

別冊

クロマトグラム

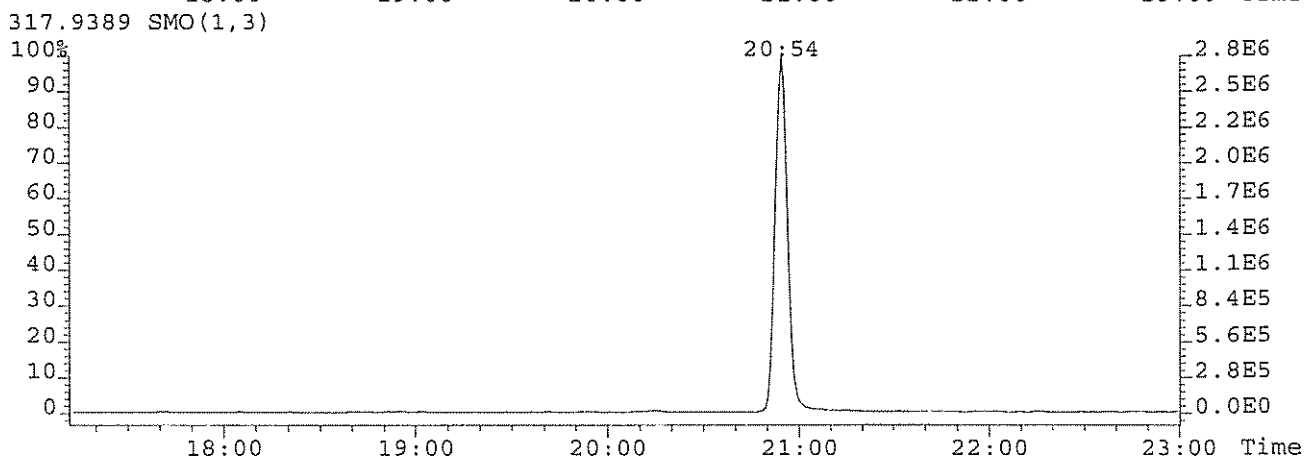
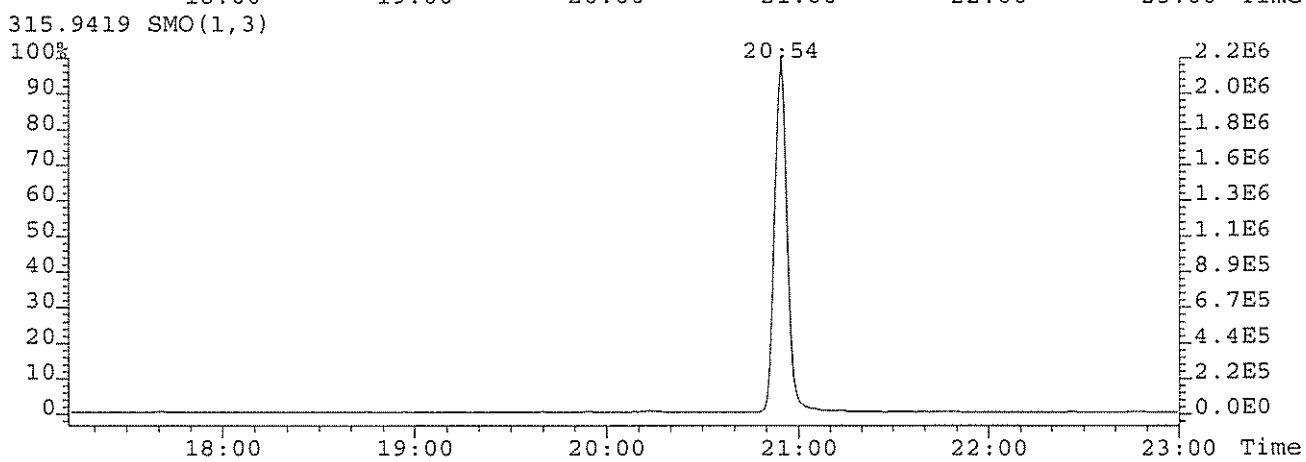
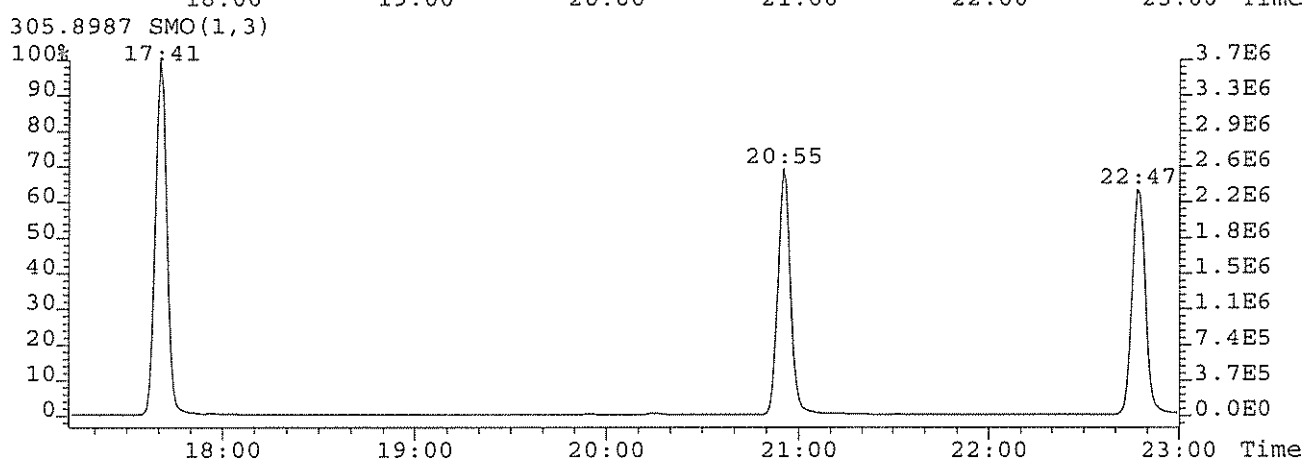
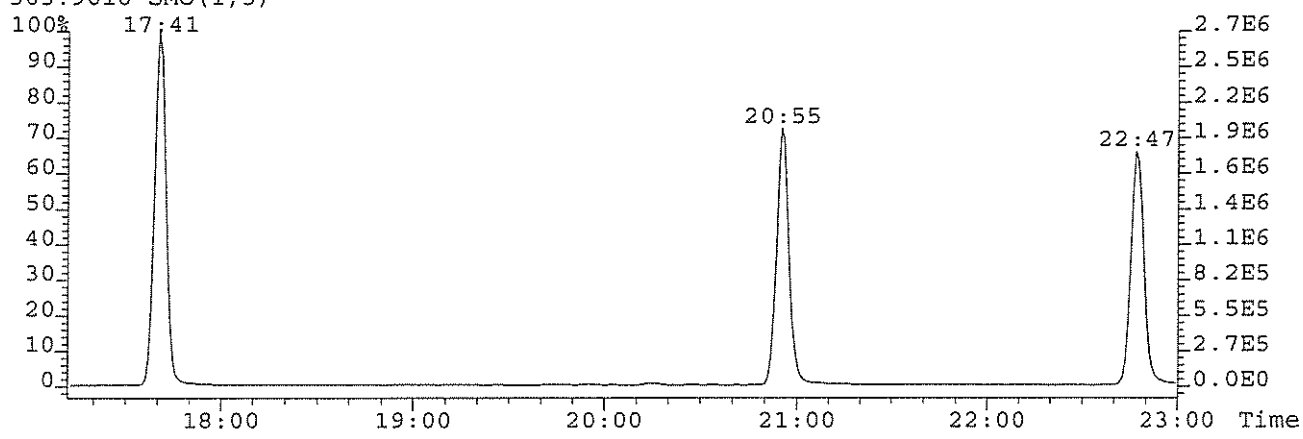
## GCMS測定日

試料管理 番号	試料名	TeCDDs/DFs～ HxCDDs/DFsの同族体及び 2,3,7,8-位塩素置換異性体	2,3,4,7,8-PeCDF, 1,2,3,7,8,9-HxCDF HpCDDs/DFs, OCDD/DFの 同族体及び 2,3,7,8-位塩素置換異性体, Non-ortho PCB	Mono-ortho PCB
XE130945	仮置土	7月12日	7月16日	7月11日
XE130946	埋設地点土壌	7月12日	7月16日	7月11日
XE130947	ドラム缶付着物No.1	7月12日	7月16日	7月11日
XE130948	ドラム缶付着物No.2	7月10日	7月11日	7月11日
XE130949	ドラム缶付着物No.3	7月10日	7月11日	7月13日
XE130950	ドラム缶付着物No.4	7月10日	7月11日	7月11日
XE130951	ドラム缶付着物No.5	7月10日	7月11日	7月13日
XE130952	ドラム缶付着物No.6	7月10日	7月11日	7月11日
XE130953	ドラム缶付着物No.7	7月12日	7月11日	7月13日
XE130954	ドラム缶付着物No.8	7月12日	7月11日	7月13日
XE130955	ドラム缶付着物No.9	7月16日	7月11日	7月13日
XE130956	ドラム缶付着物No.10	7月12日	7月11日	7月13日
XE130957	ドラム缶付着物No.11	7月12日	7月11日	7月13日
XE130958	ドラム缶付着物No.12	7月16日	7月11日	7月13日
XE130959	ドラム缶付着物No.13	7月16日	7月17日	7月13日
XE130960	ドラム缶付着物No.14	7月12日	7月11日	7月13日
XE130961	ドラム缶付着物No.15	7月12日	7月13日	7月13日
XE130962	ドラム缶付着物No.16	7月12日	7月13日	7月16日
XE130963	ドラム缶付着物No.17	7月12日	7月13日	7月16日
XE130964	ドラム缶付着物No.18	7月12日	7月13日	7月16日
XE130965	ドラム缶付着物No.19	7月12日	7月13日	7月17日
XE130966	ドラム缶付着物No.20	7月12日	7月13日	7月13日
XE130967	ドラム缶付着物No.21	7月12日	7月13日	7月13日
XE130968	ドラム缶付着物No.22	7月12日	7月13日	7月13日
XB130969	ドラム缶付着物(水)	7月12日	7月11日	7月11日

標準物質

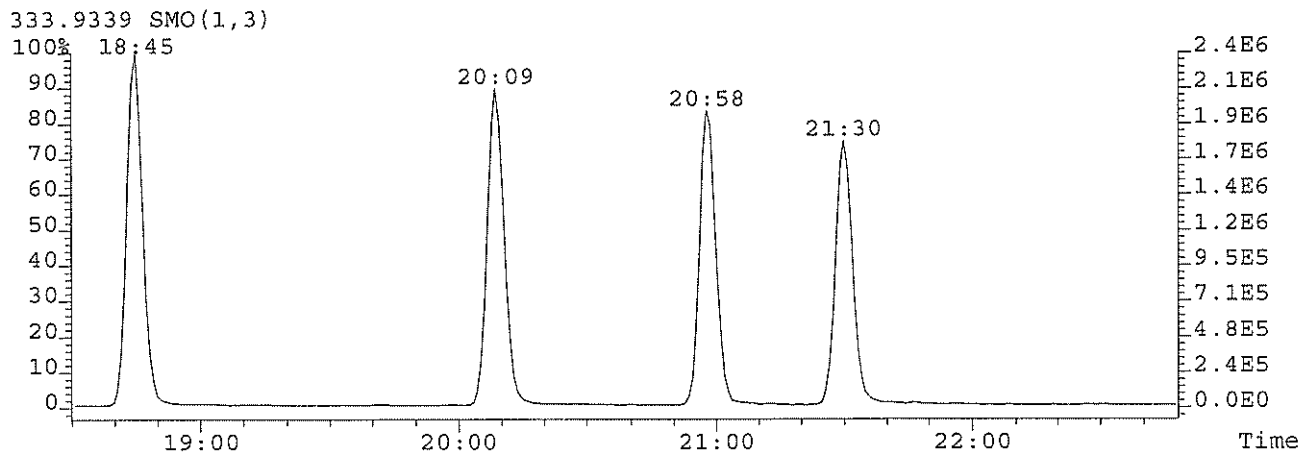
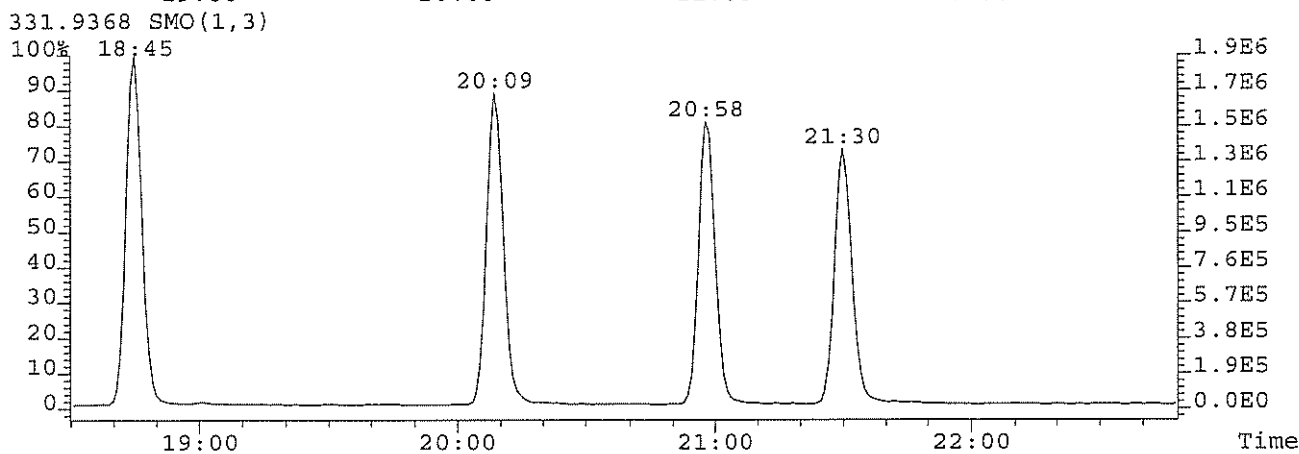
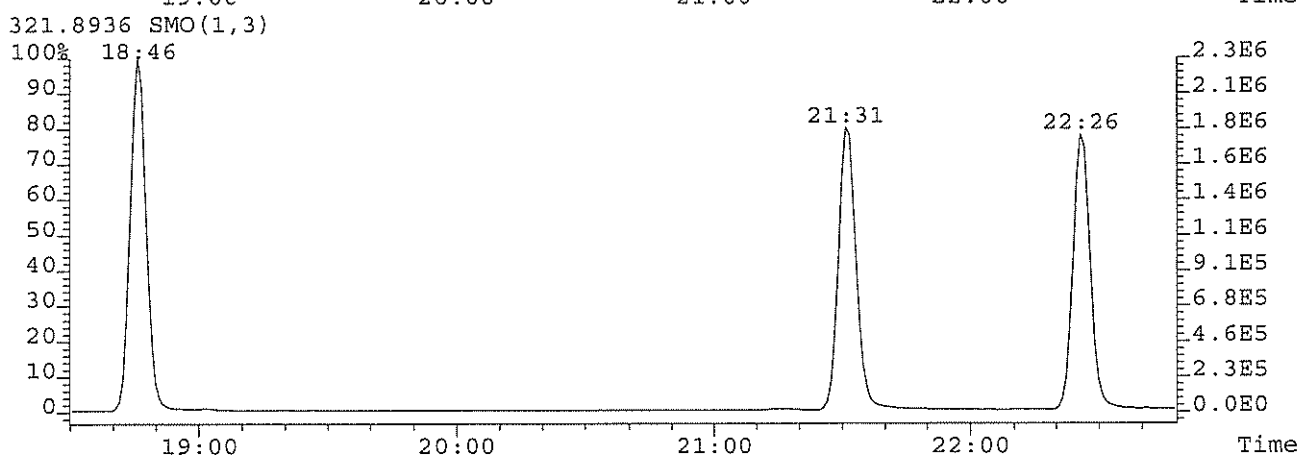
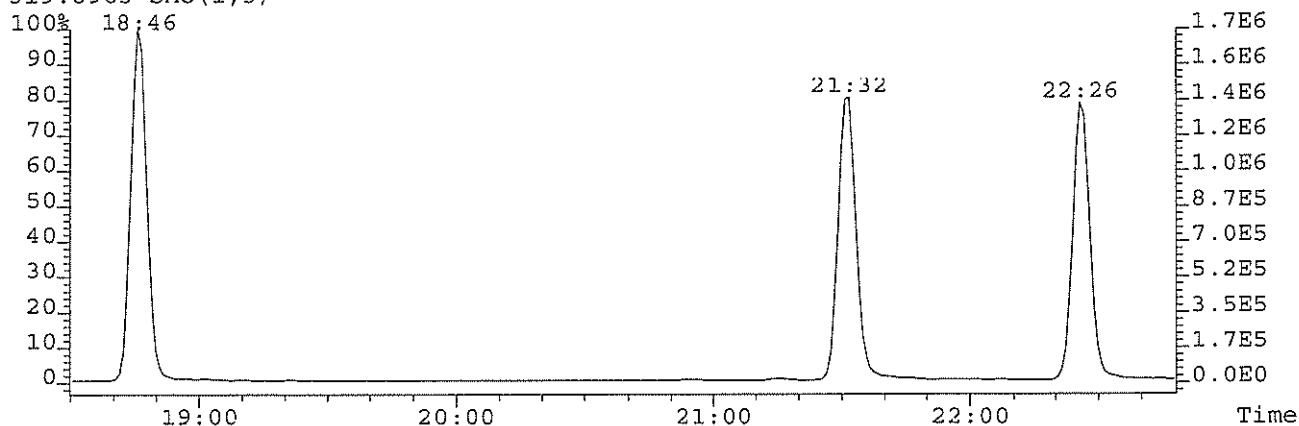
標準物質	
測定日	平成25年7月10日
測定物質	TeCDDs/DFs～HxCDDs/DFsの同族体及び 2,3,7,8-位塩素置換異性体

File:130710 #1-1577 Acq:10-JUL-2013 10:59:14 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX04  
303.9016 SMO(1,3)



PCDFsクロマトグラム (1)  
(TeCDFs)

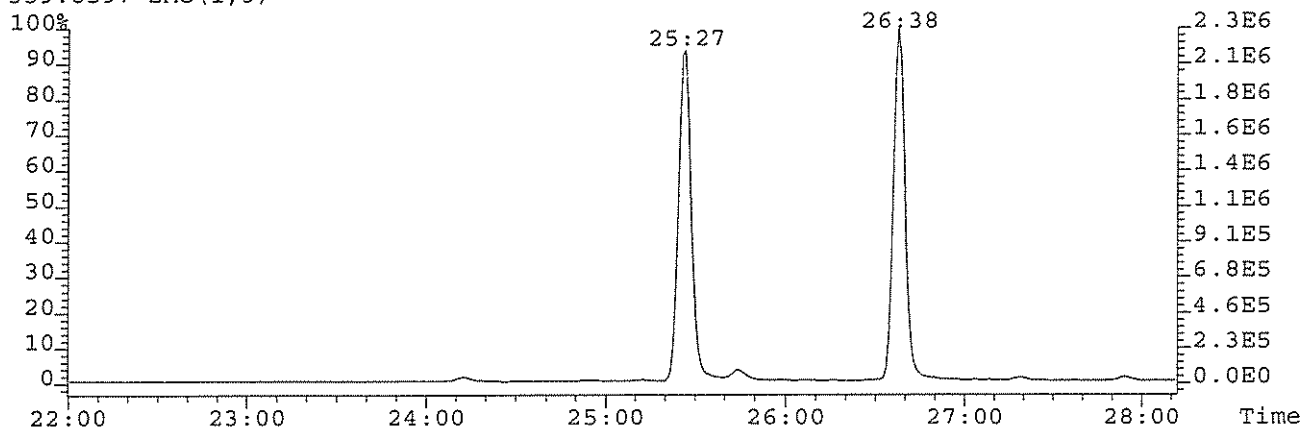
File:130710 #1-1577 Acq:10-JUL-2013 10:59:14 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX04  
319.8965 SMO(1,3)



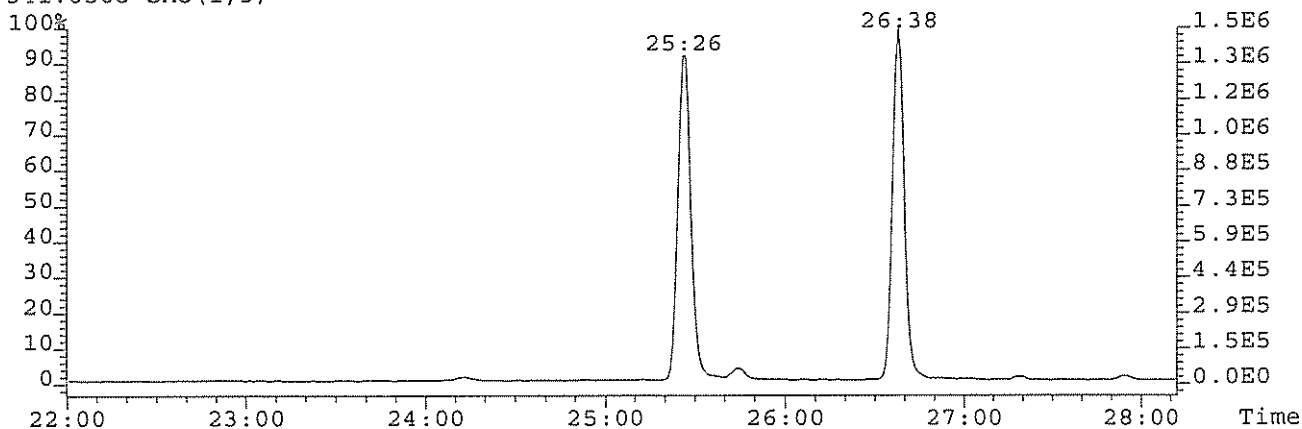
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130710 #1-1577 Acq:10-JUL-2013 10:59:14 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX04

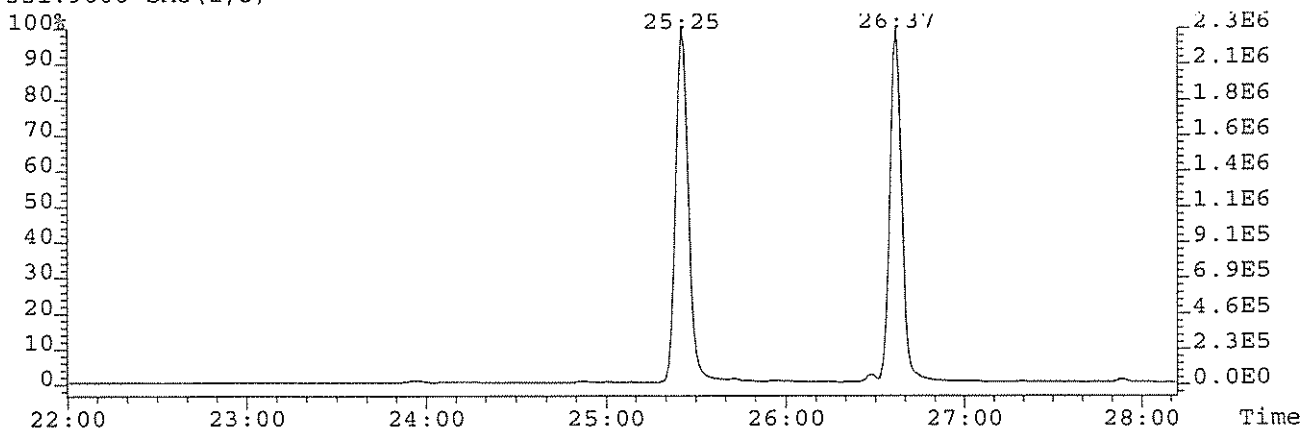
339.8597 SMO(1,3)



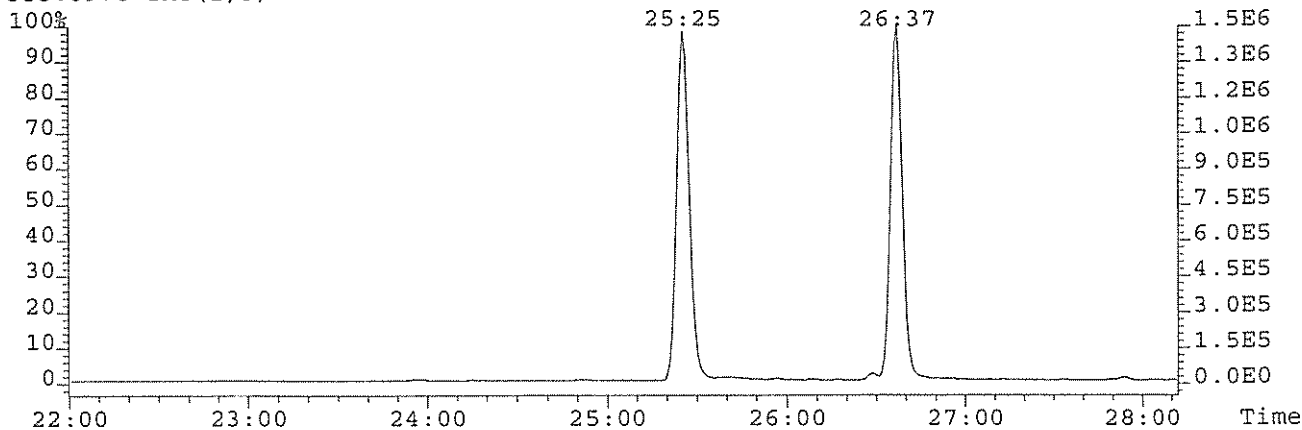
341.8568 SMO(1,3)



351.9000 SMO(1,3)



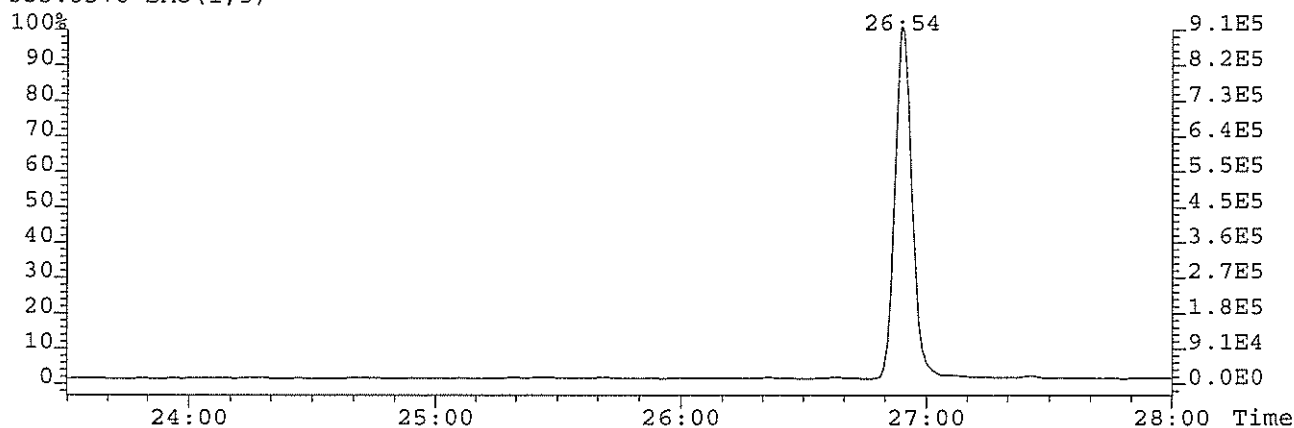
353.8970 SMO(1,3)



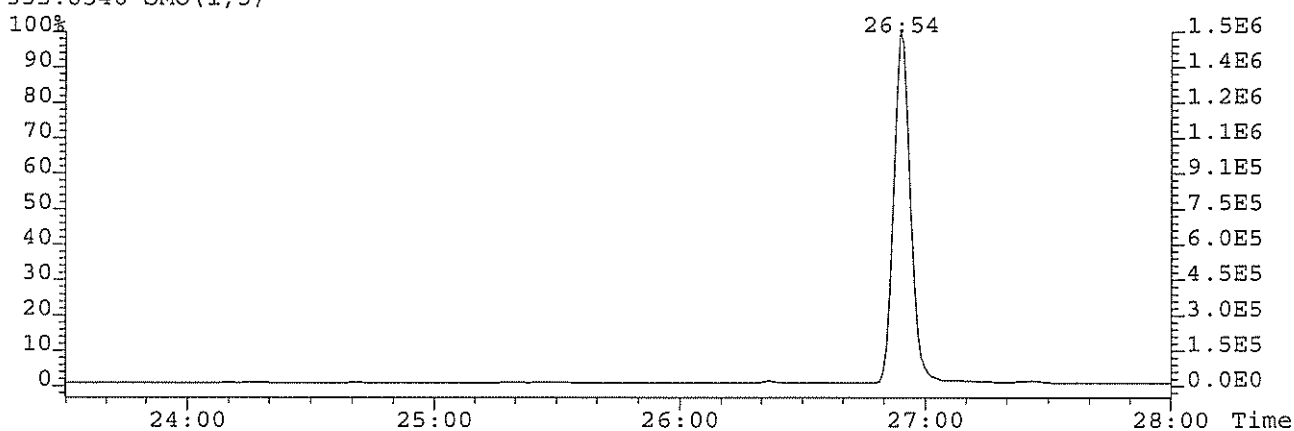
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130710 #1-1577 Acq:10-JUL-2013 10:59:14 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX04

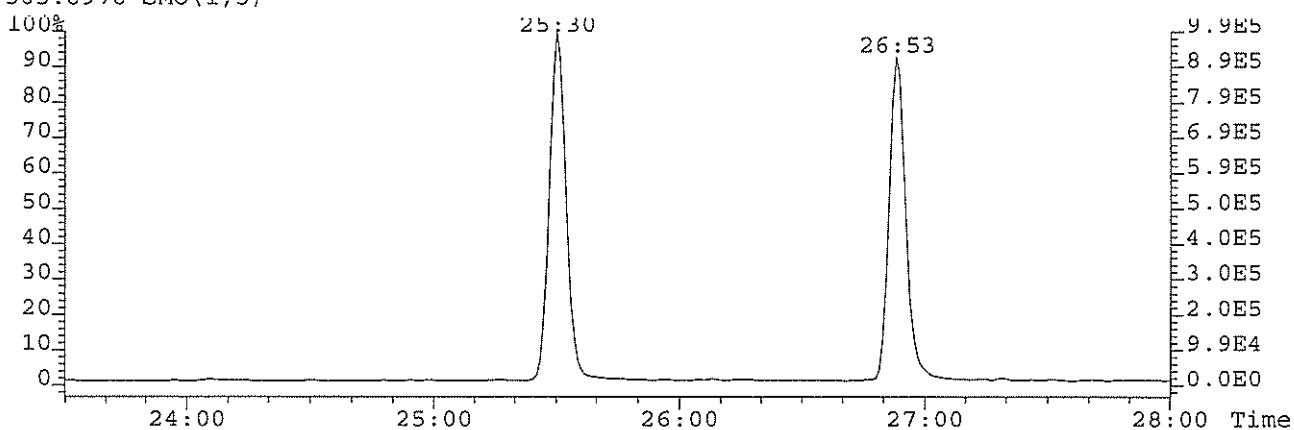
353.8576 SMO(1,3)



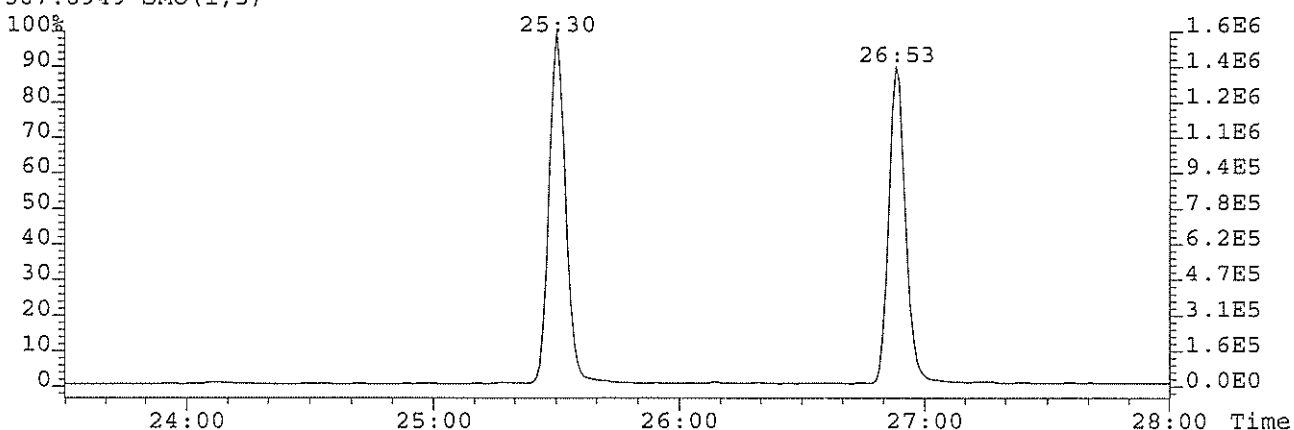
355.8546 SMO(1,3)



365.8978 SMO(1,3)



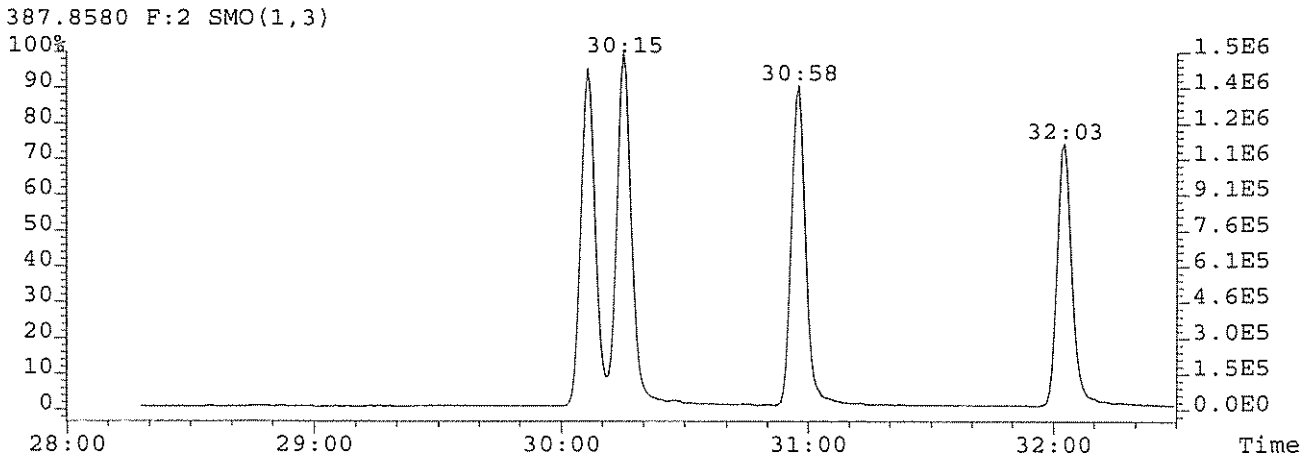
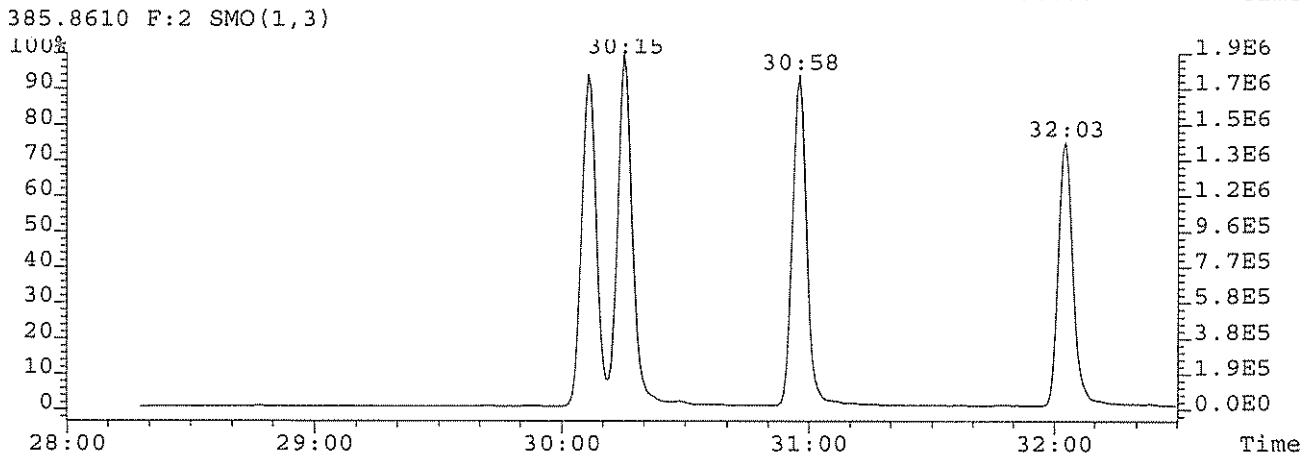
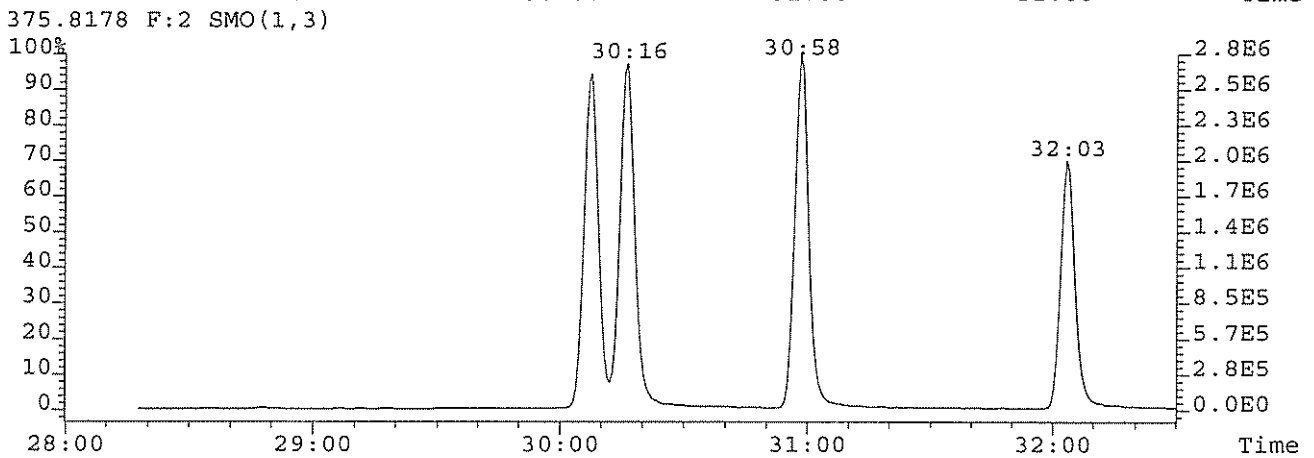
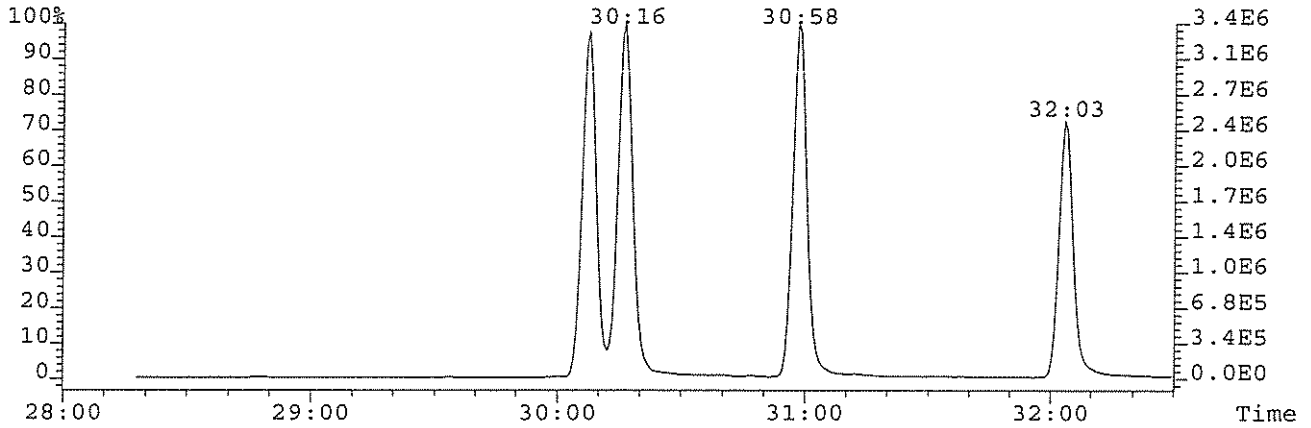
367.8949 SMO(1,3)



PCDDsクロマトグラム (4)  
(PeCDDs)

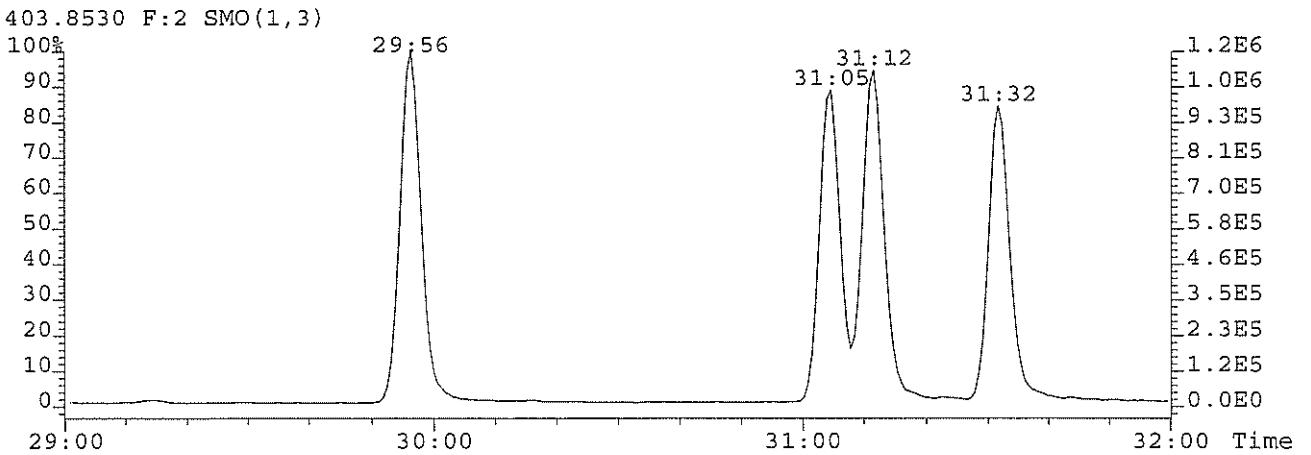
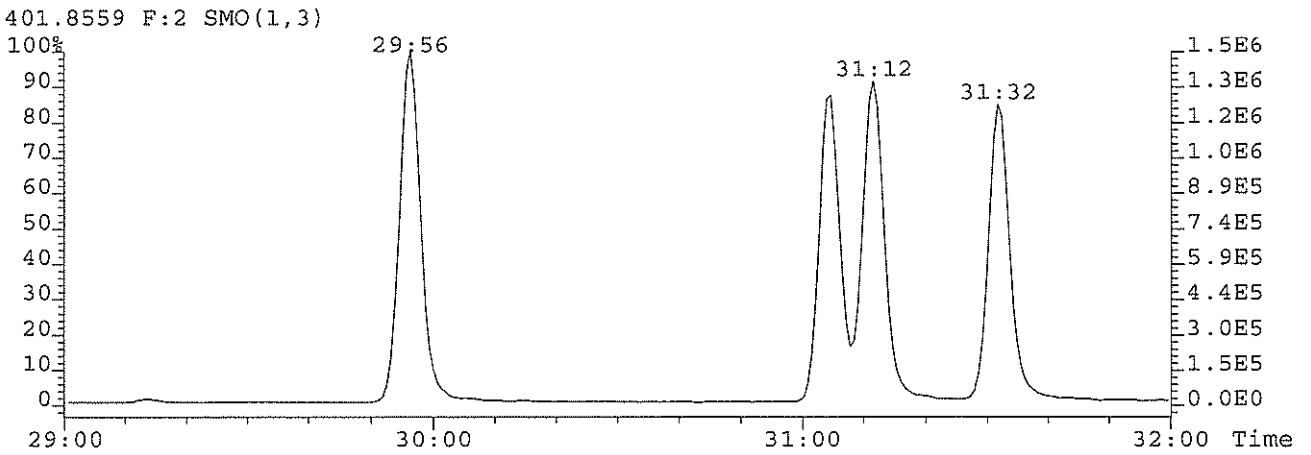
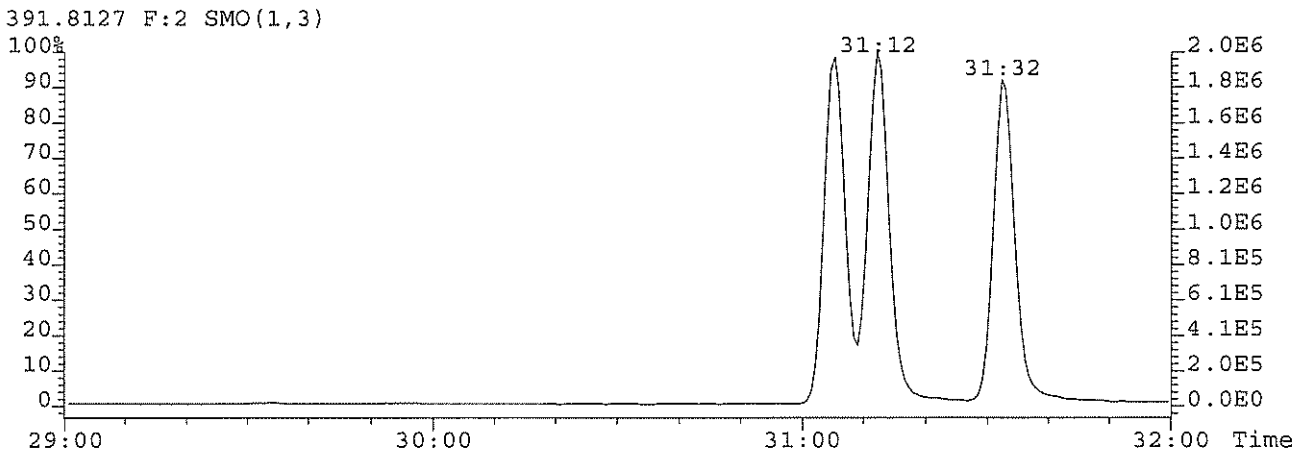
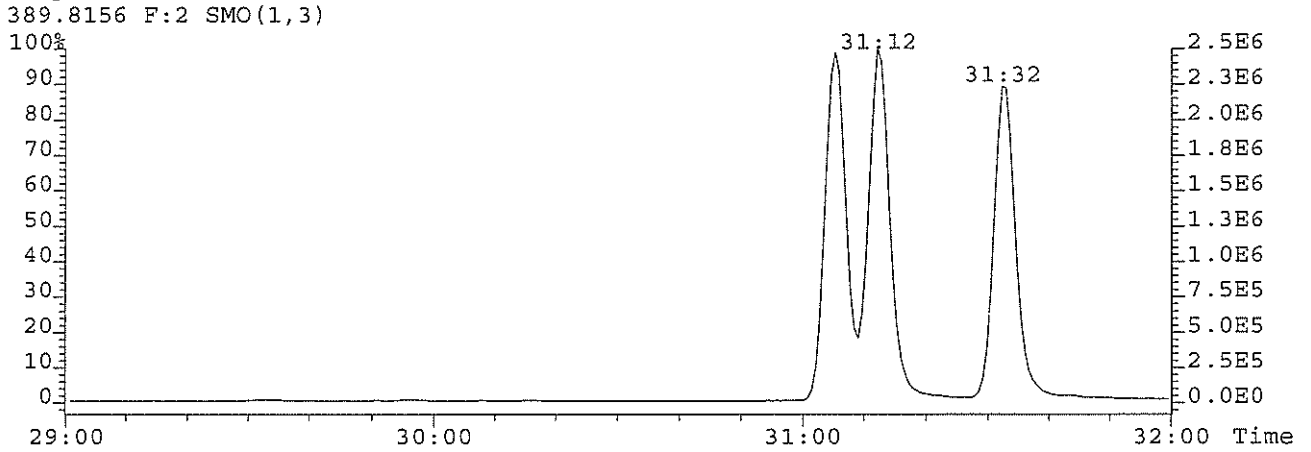


File:130710 #1-1117 Acq:10-JUL-2013 10:59:14 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX04  
373.8207 F:2 SMO(1,3)



PCDFsクロマトグラム (5)  
(HxCDFs)

File:130710 #1-1117 Acq:10-JUL-2013 10:59:14 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX04

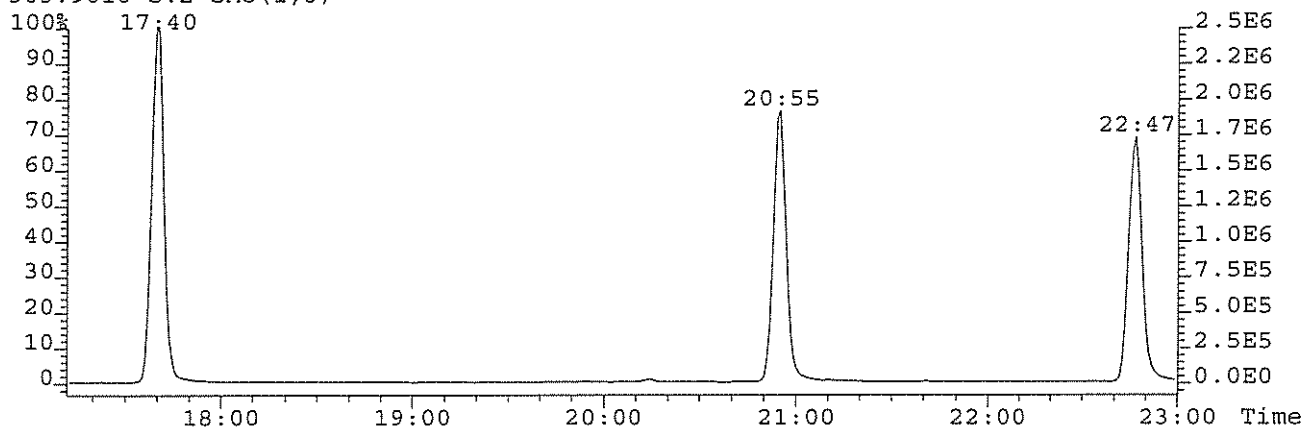


PCDDsクロマトグラム (6)  
(HxCDDs)

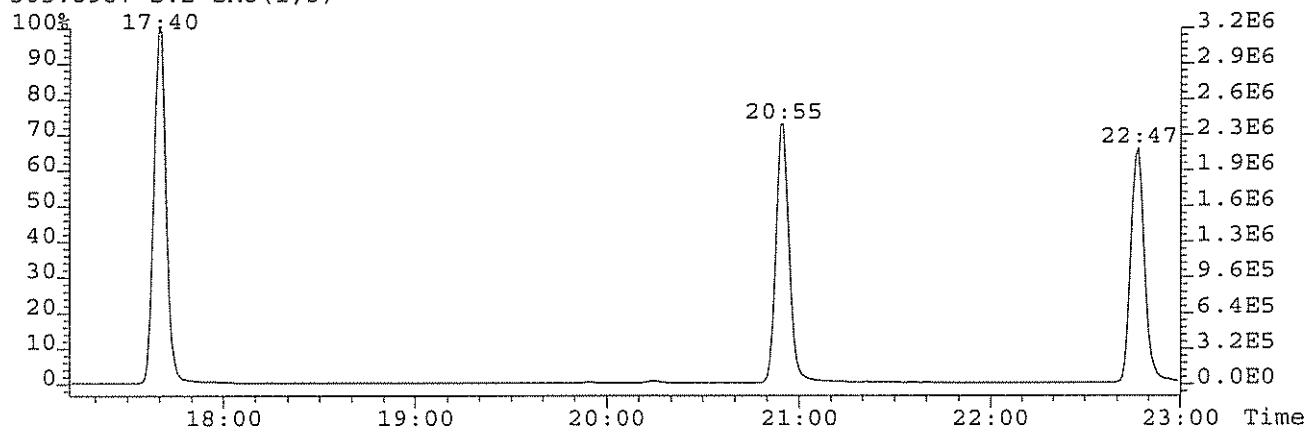
標準物質	
測定日	平成25年7月12日
測定物質	TeCDDs/DFs～HxCDDs/DFsの同族体及び 2,3,7,8-位塩素置換異性体

File:130712 #1-1577 Acq:12-JUL-2013 12:23:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX04

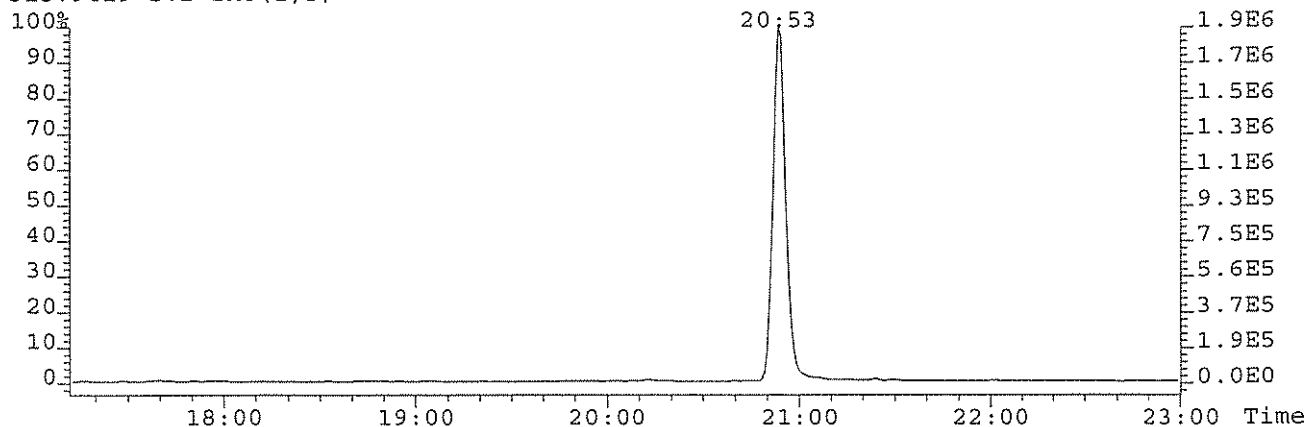
303.9016 S:2 SMO(1,3)



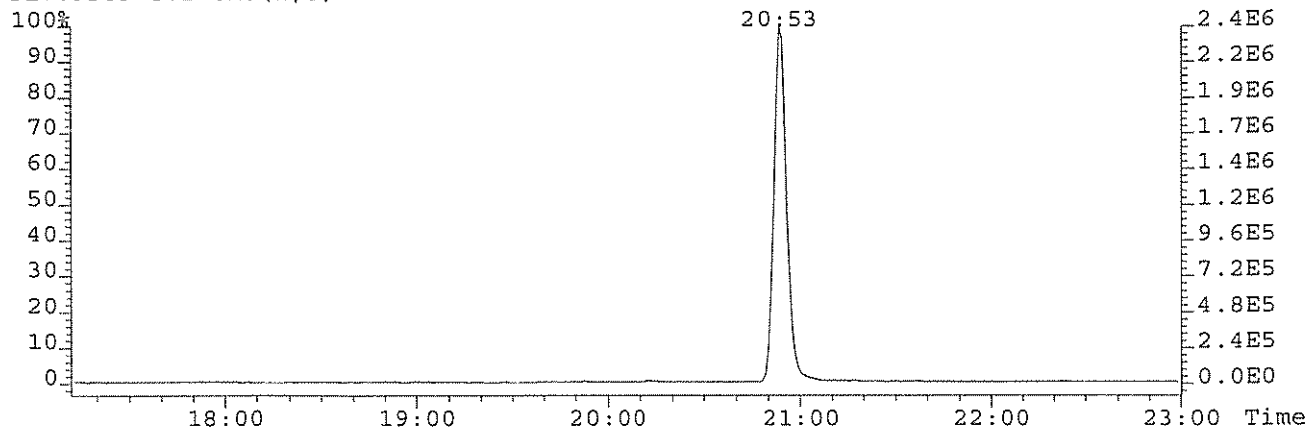
305.8987 S:2 SMO(1,3)



315.9419 S:2 SMO(1,3)



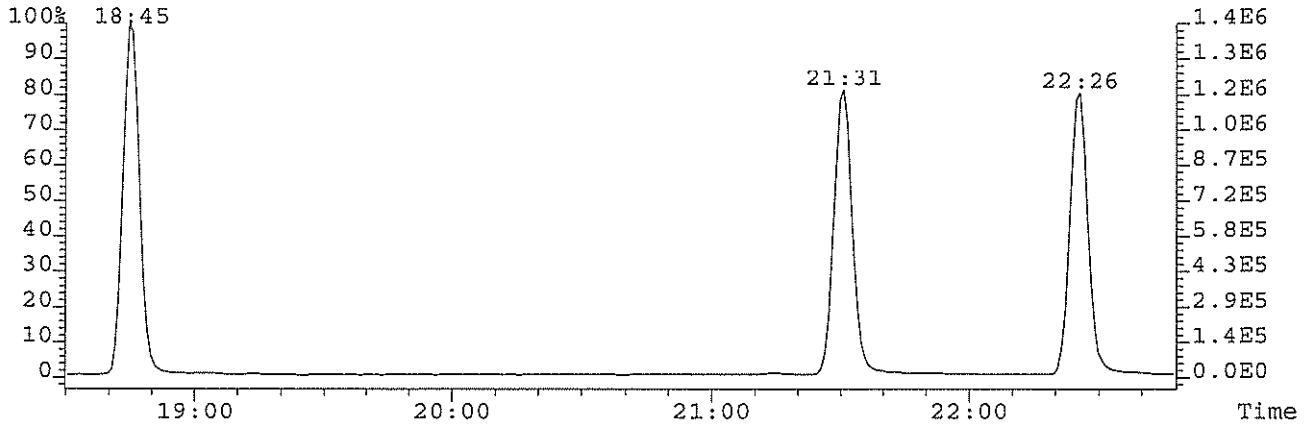
317.9389 S:2 SMO(1,3)



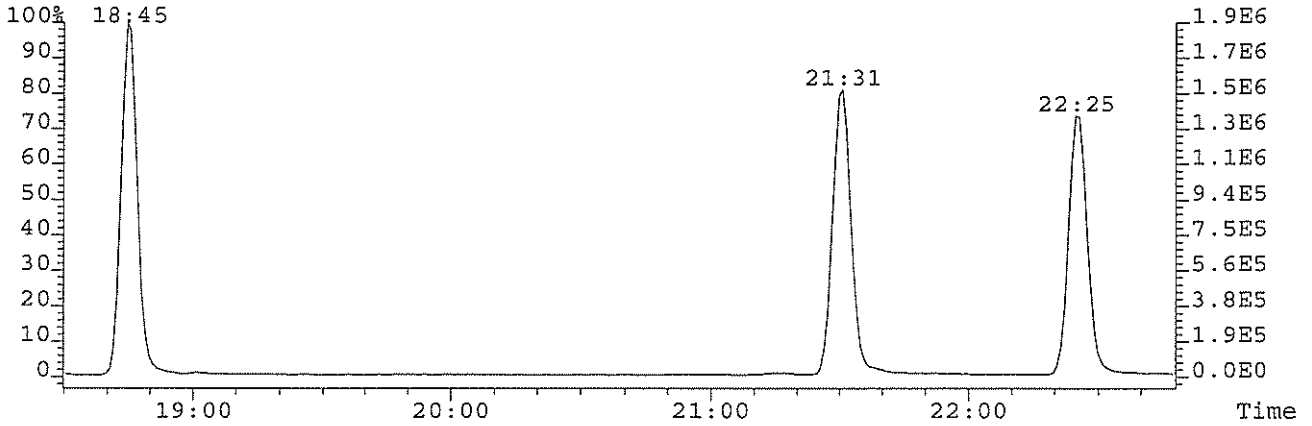
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130712 #1-1577 Acq:12-JUL-2013 12:23:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX04

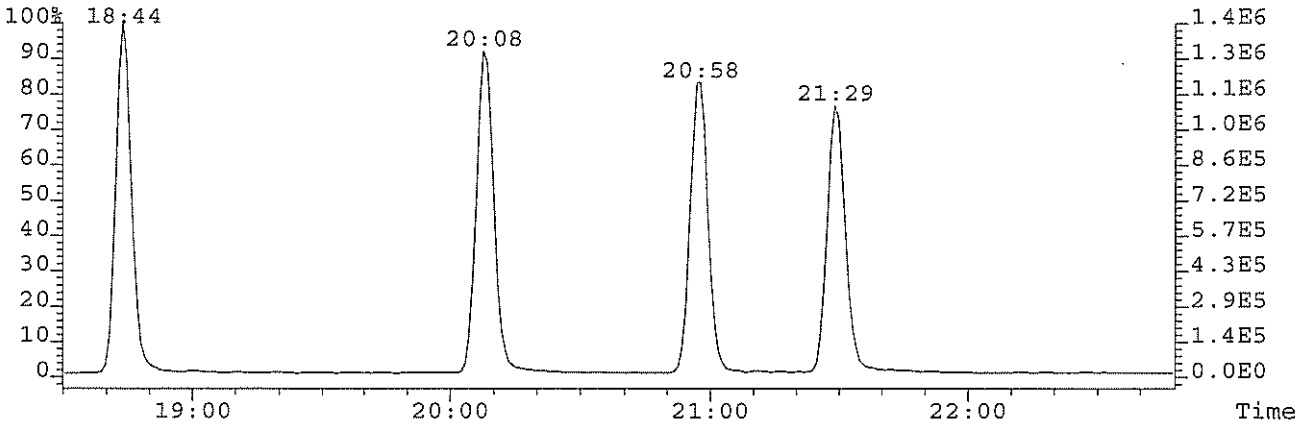
319.8965 S:2 SMO(1,3)



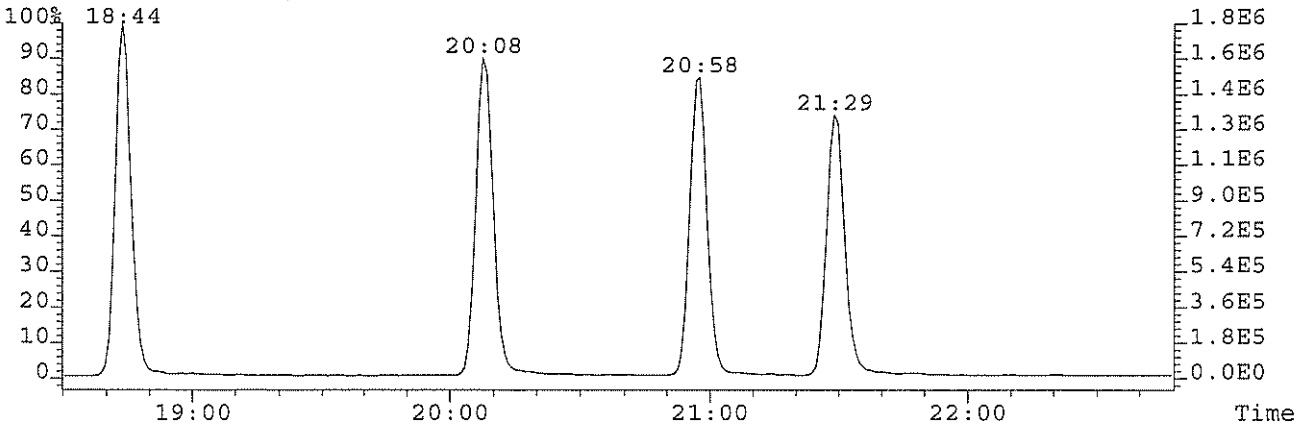
321.8936 S:2 SMO(1,3)



331.9368 S:2 SMO(1,3)

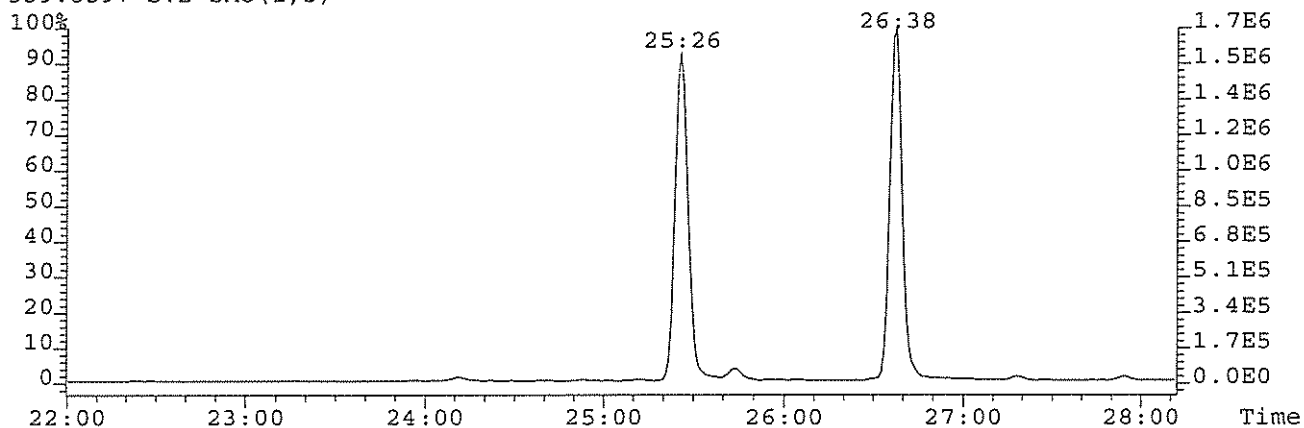


333.9339 S:2 SMO(1,3)

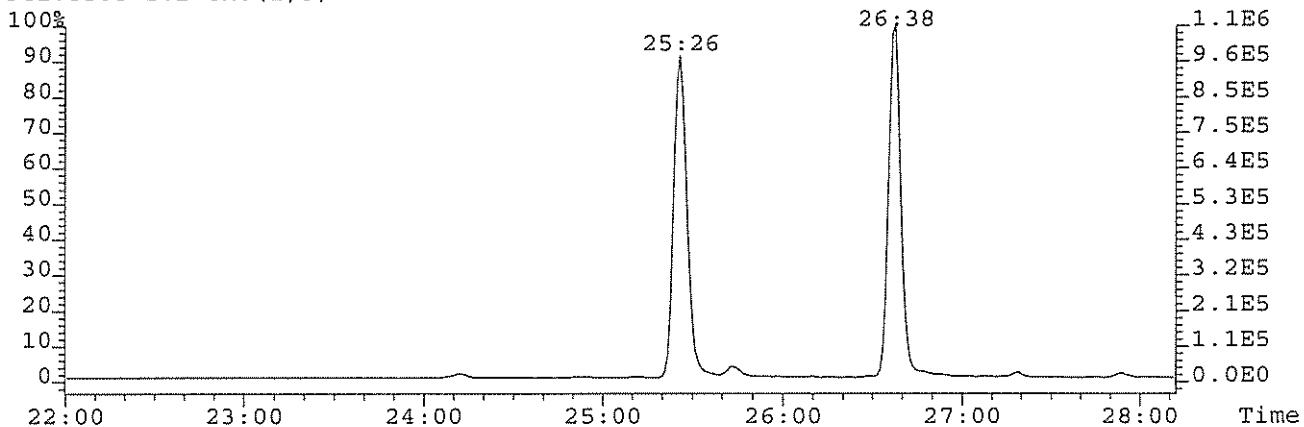


PCDDsクロマトグラム (2)  
(TeCDDs)

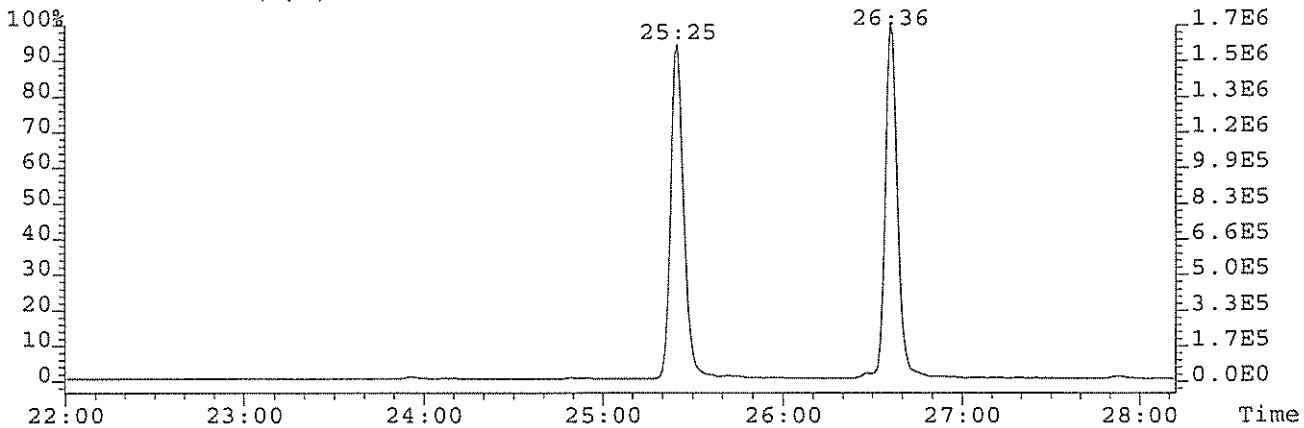
File:130712 #1-1577 Acq:12-JUL-2013 12:23:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX04  
339.8597 S:2 SMO(1,3)



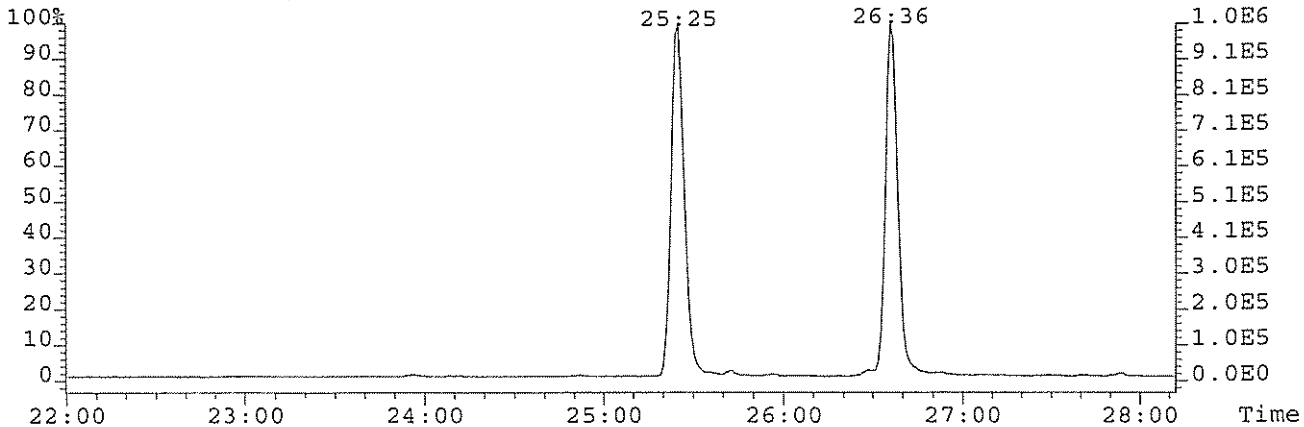
341.8568 S:2 SMO(1,3)



351.9000 S:2 SMO(1,3)



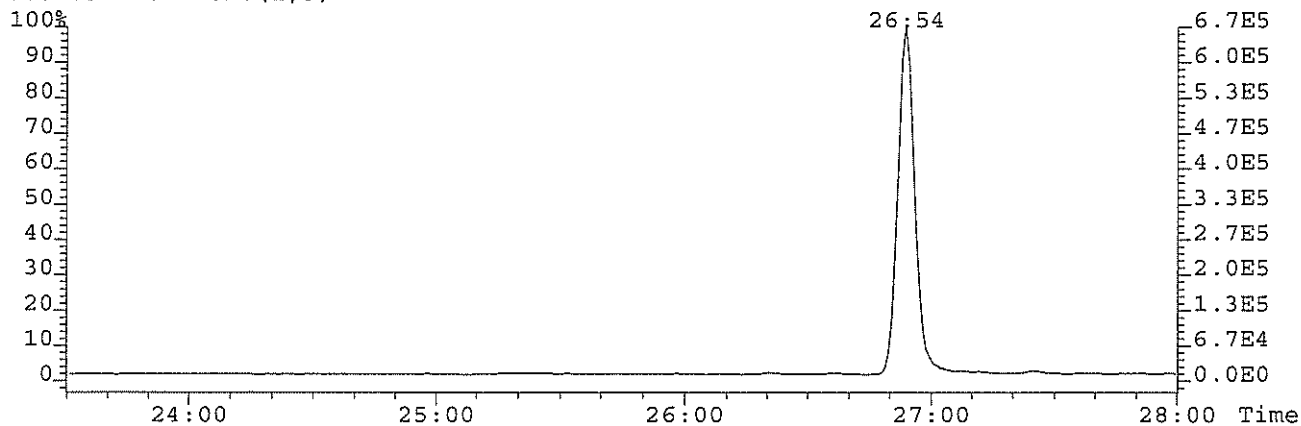
353.8970 S:2 SMO(1,3)



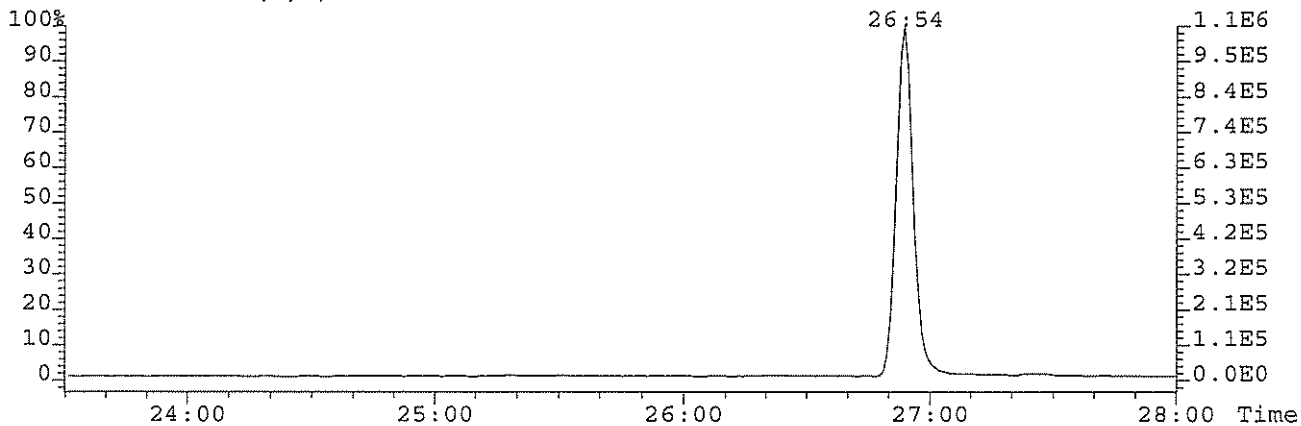
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712 #1-1577 Acq:12-JUL-2013 12:23:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX04

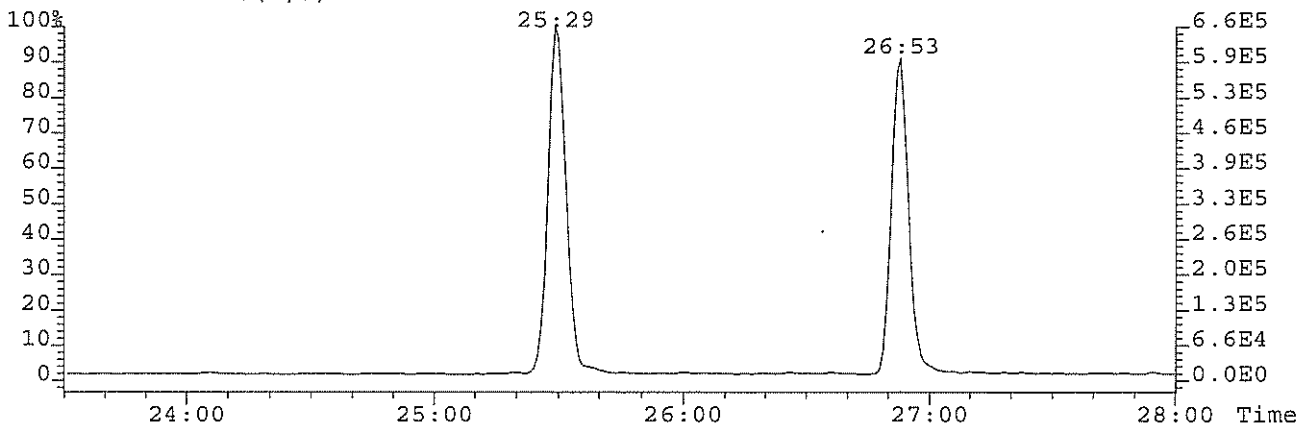
353.8576 S:2 SMO(1,3)



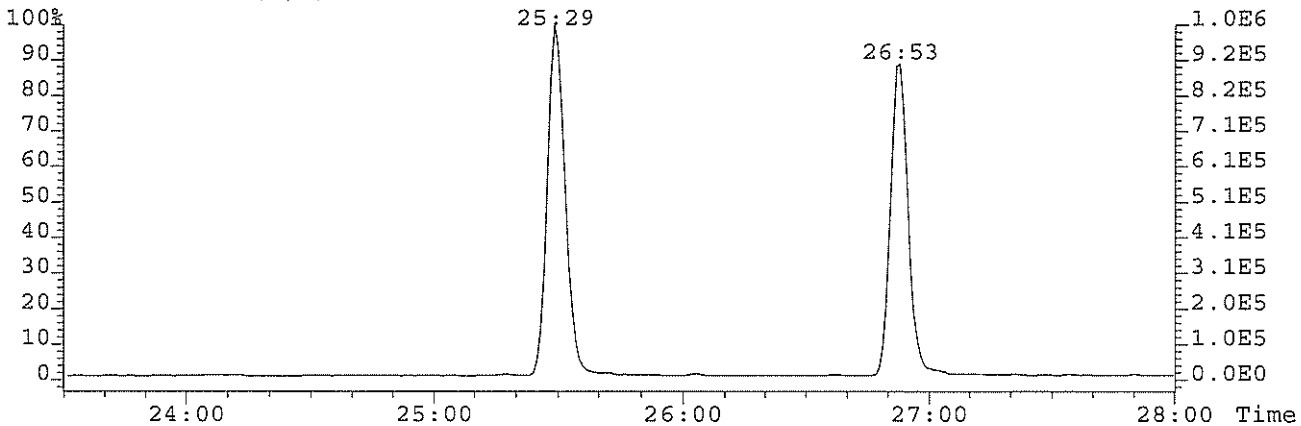
355.8546 S:2 SMO(1,3)



365.8978 S:2 SMO(1,3)

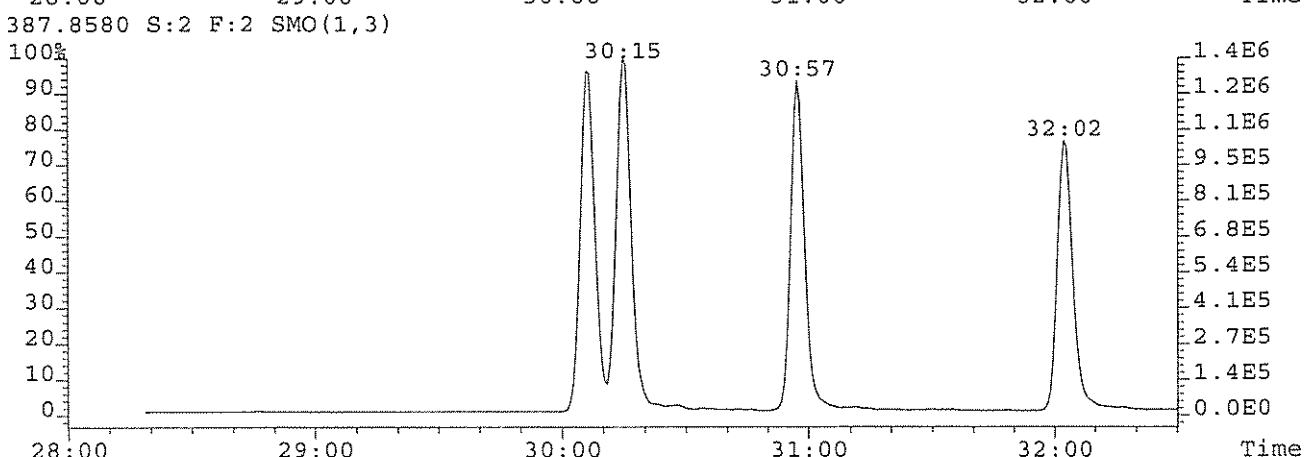
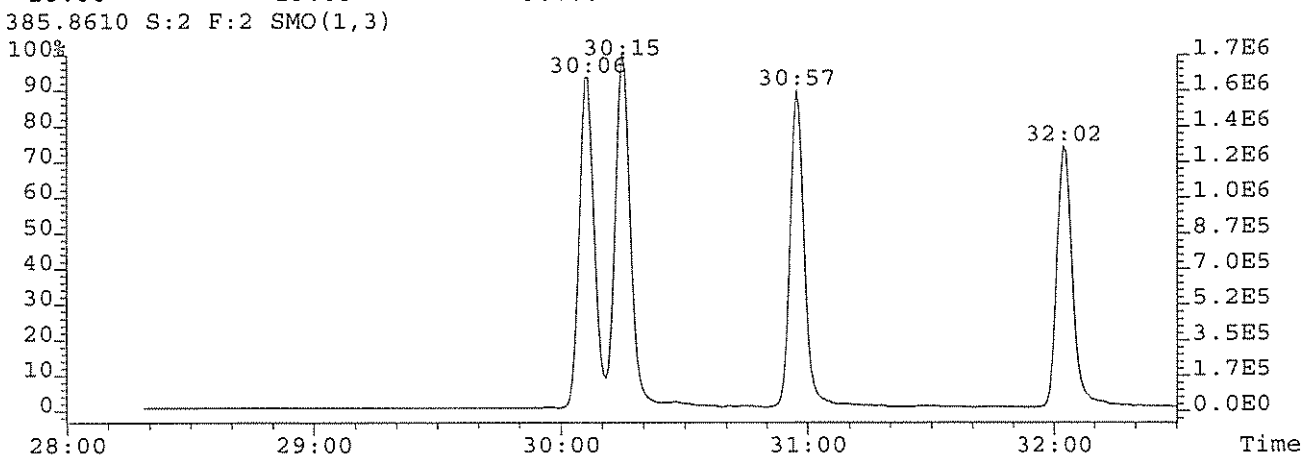
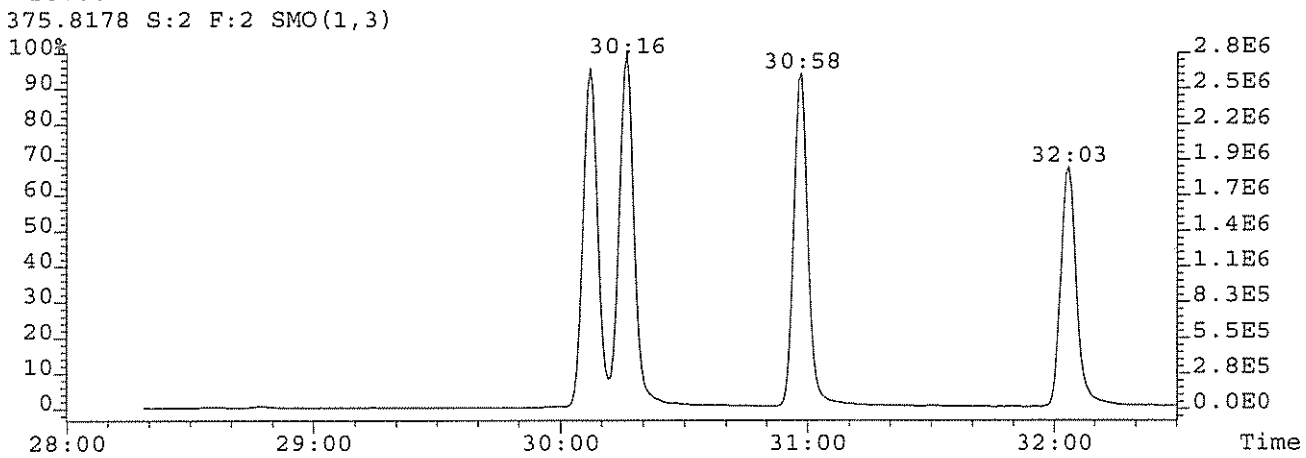
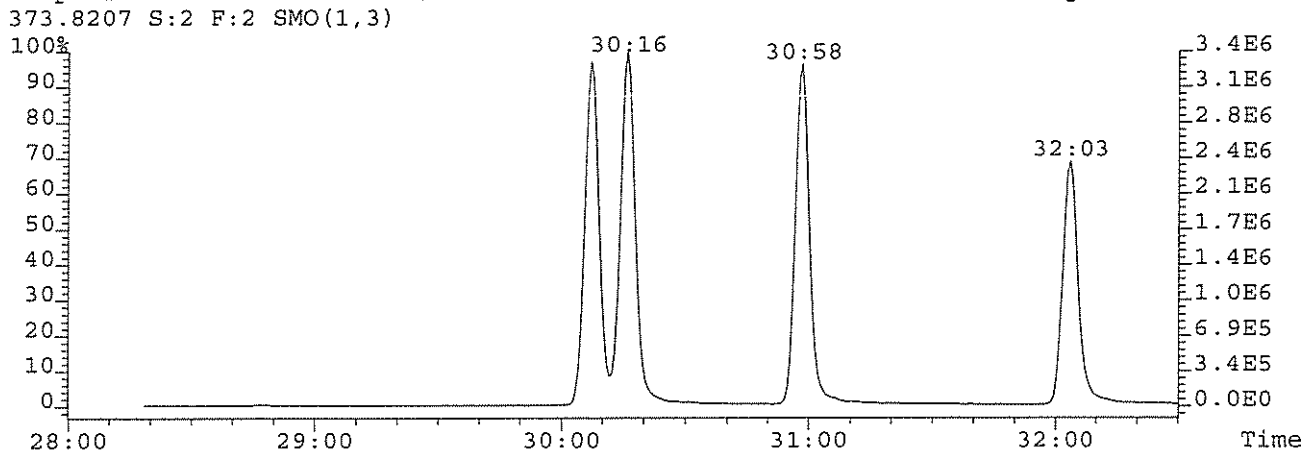


367.8949 S:2 SMO(1,3)



PCDDsクロマトグラム (4)  
(PeCDDs)

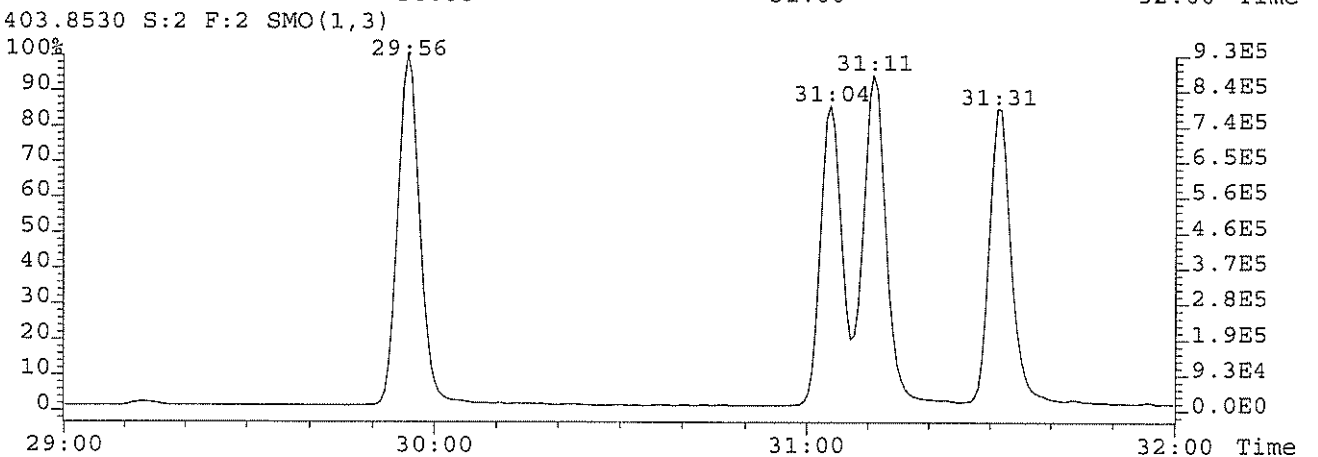
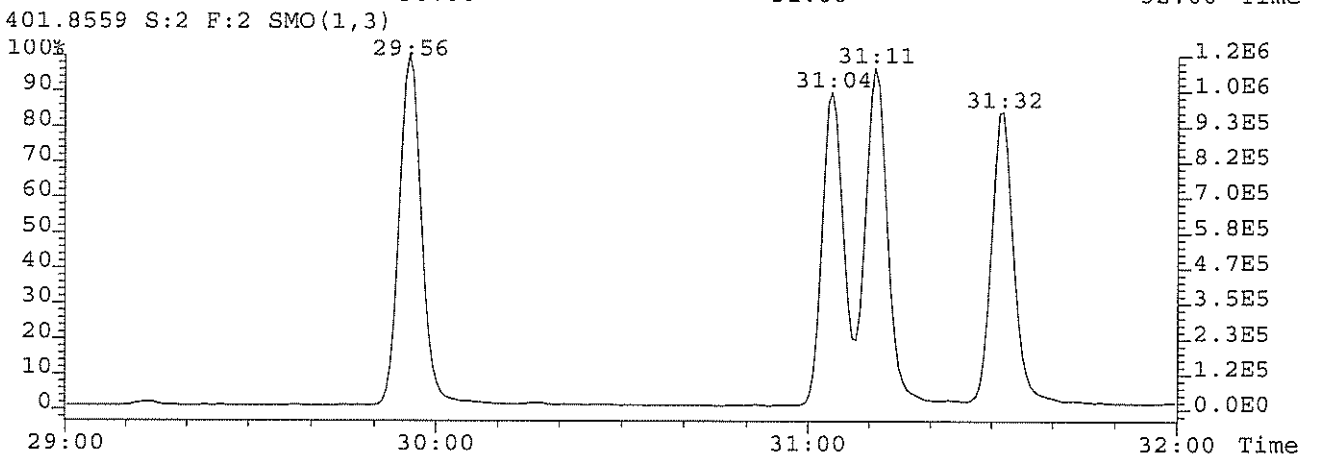
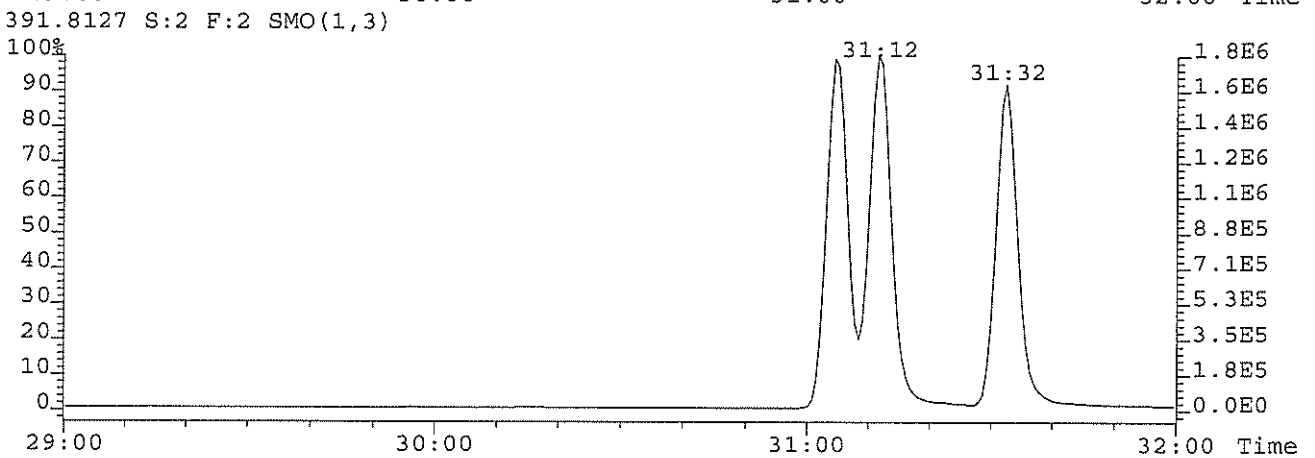
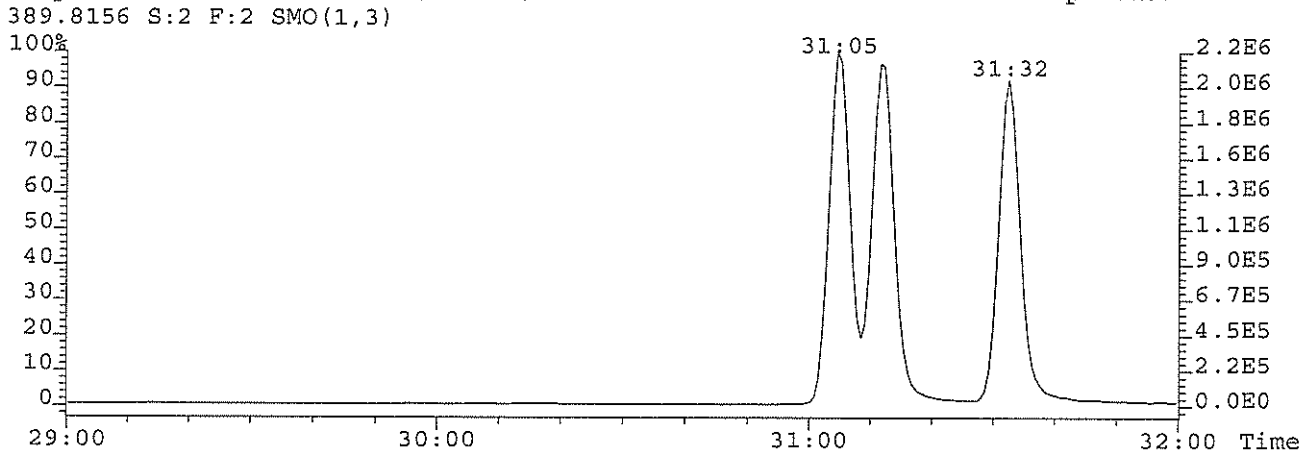
File:130712 #1-1117 Acq:12-JUL-2013 12:23:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX04



PCDFsクロマトグラム (5)  
(HxCDFs)



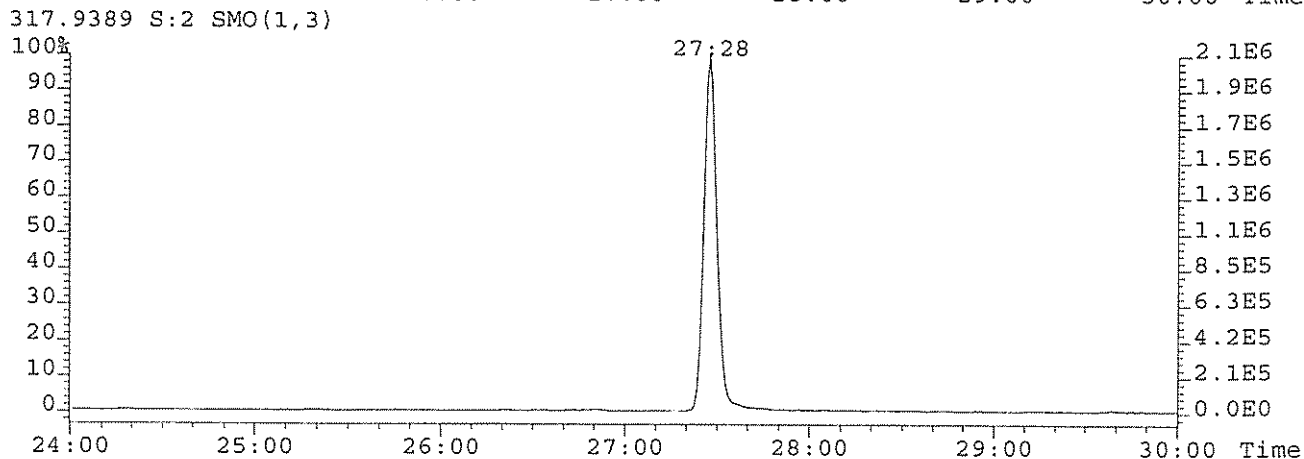
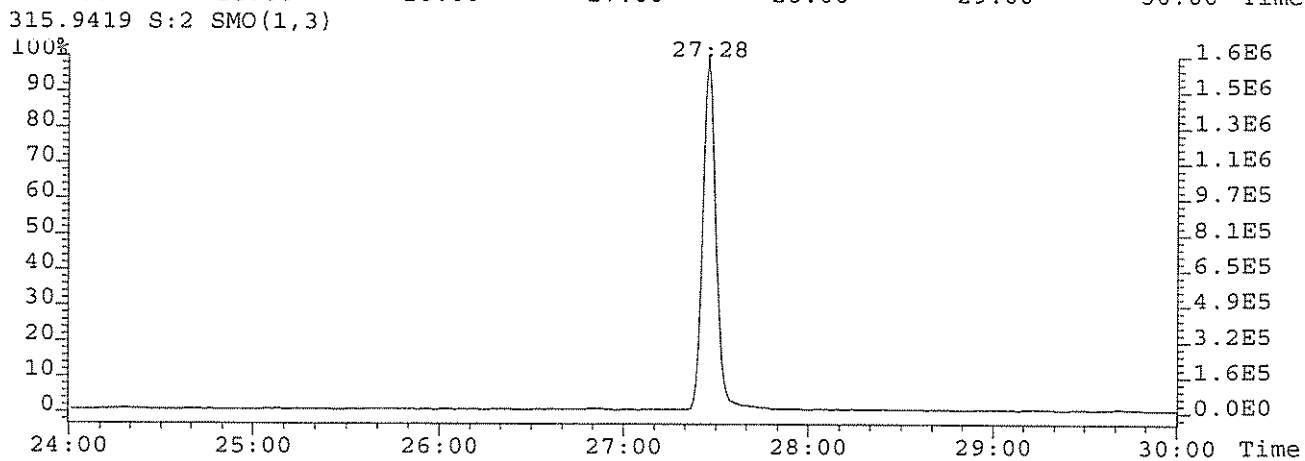
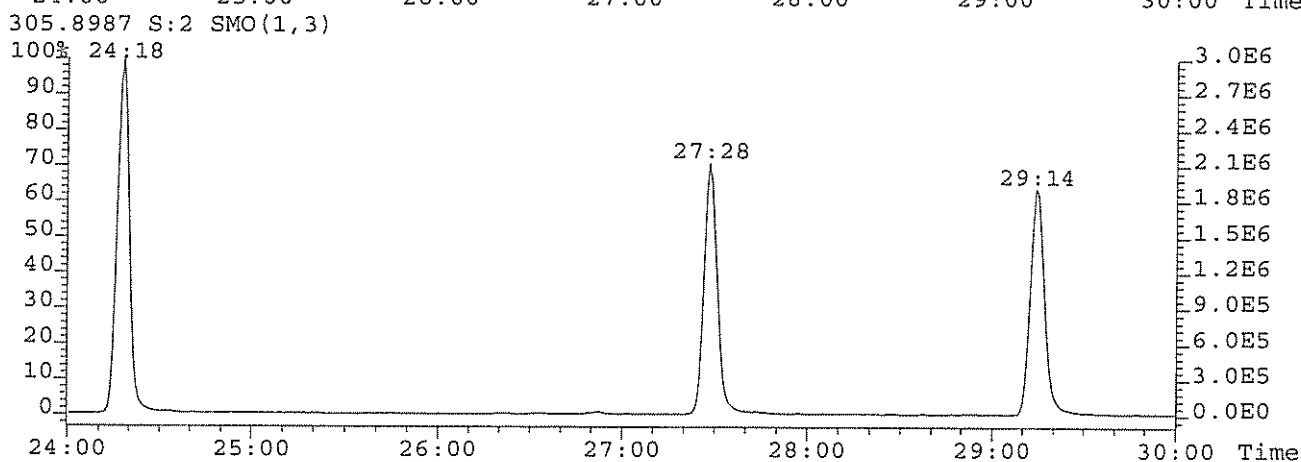
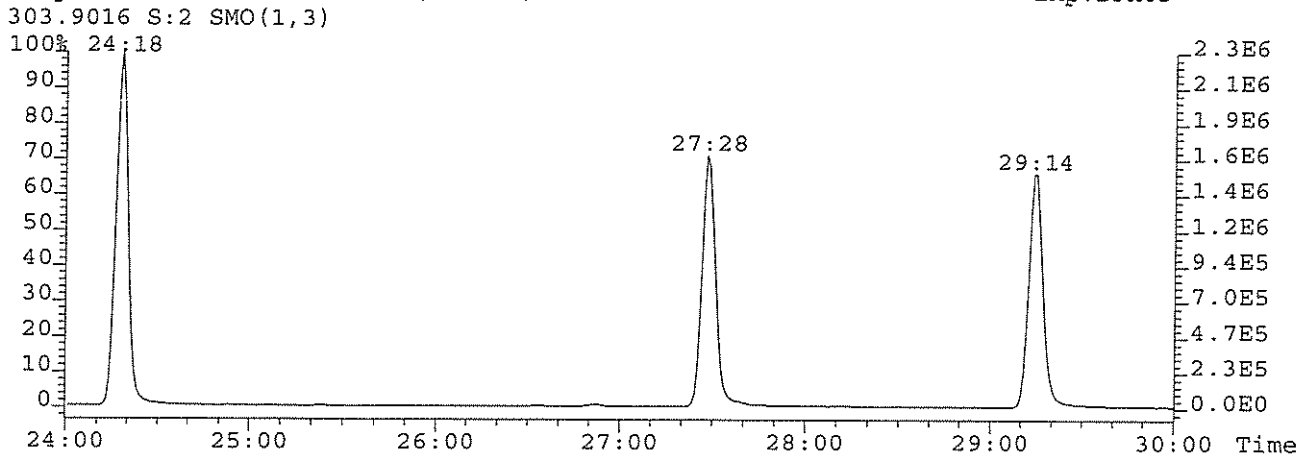
File:130712 #1-1117 Acq:12-JUL-2013 12:23:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX04



PCDDsクロマトグラム (6)  
(HxCDDs)

標準物質	
測定日	平成25年7月16日
測定物質	TeCDDs/DFs～HxCDDs/DFsの同族体及び 2,3,7,8-位塩素置換異性体

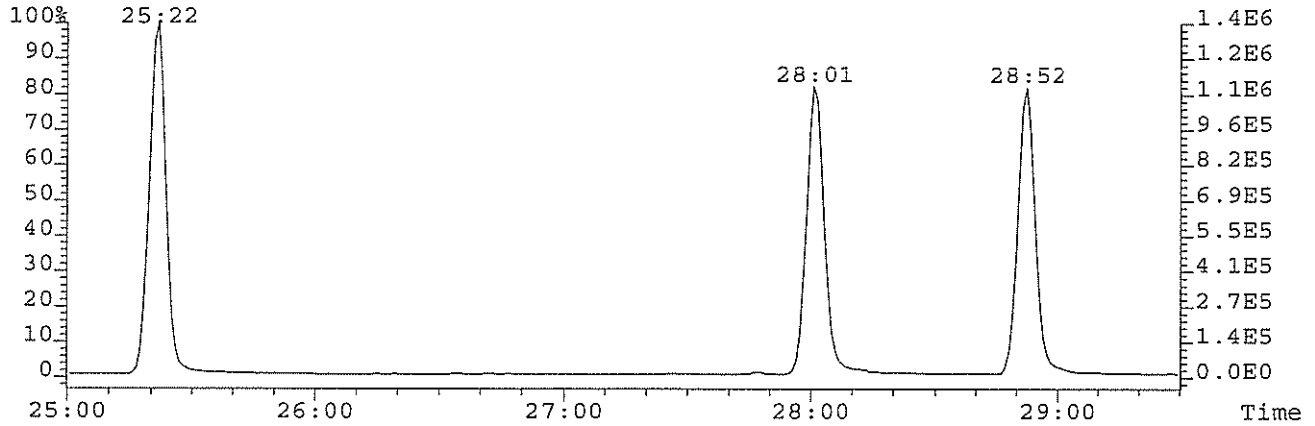
File:130716 #1-2009 Acq:16-JUL-2013 12:48:55 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX03



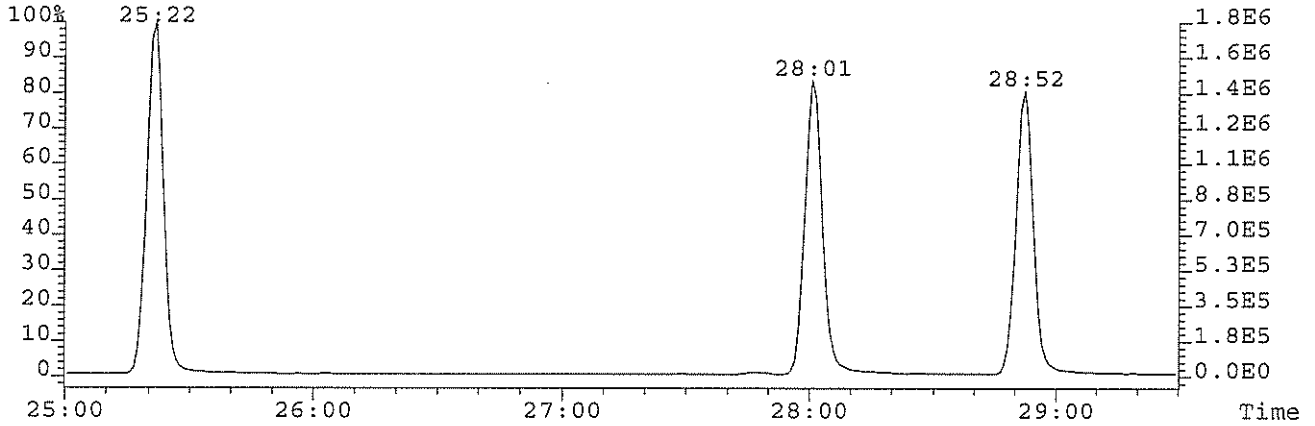
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130716 #1-2009 Acq:16-JUL-2013 12:48:55 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX03

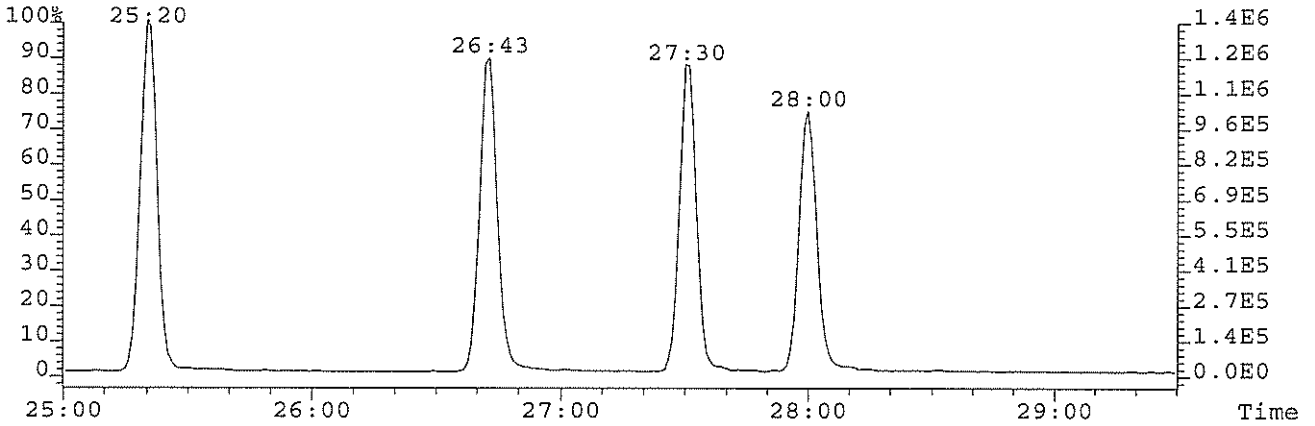
319.8965 S:2 SMO(1,3)



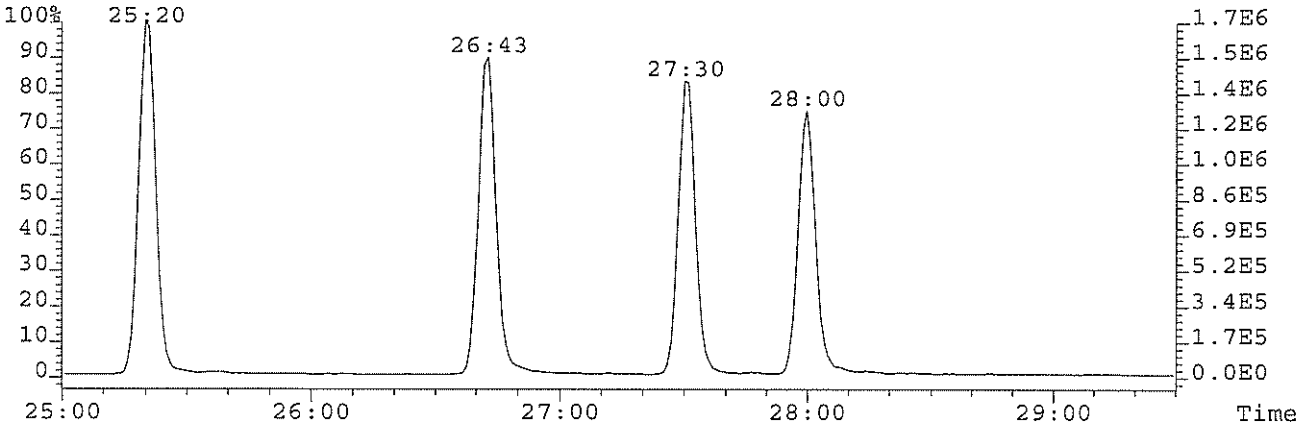
321.8936 S:2 SMO(1,3)



331.9368 S:2 SMO(1,3)



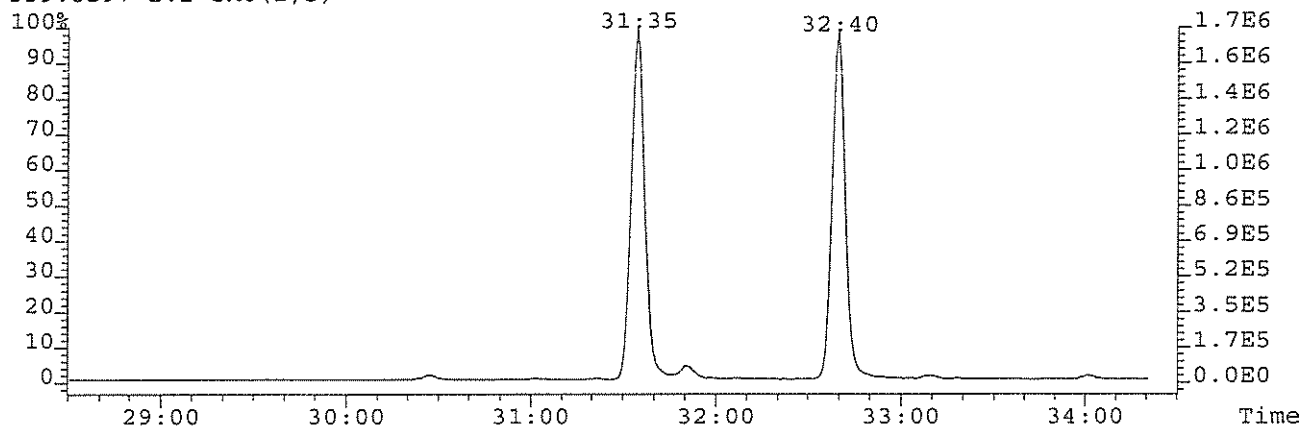
333.9339 S:2 SMO(1,3)



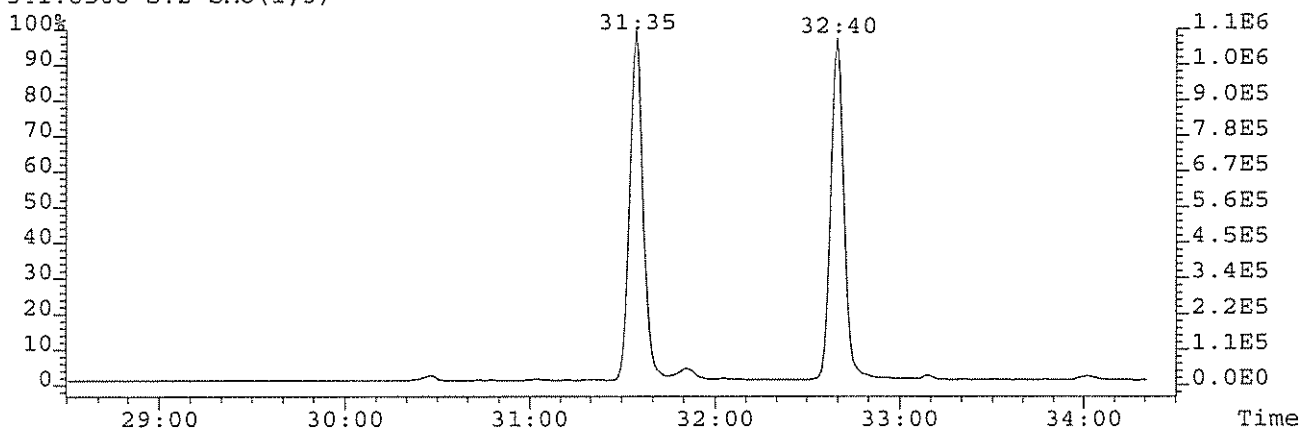
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130716 #1-2009 Acq:16-JUL-2013 12:48:55 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX03

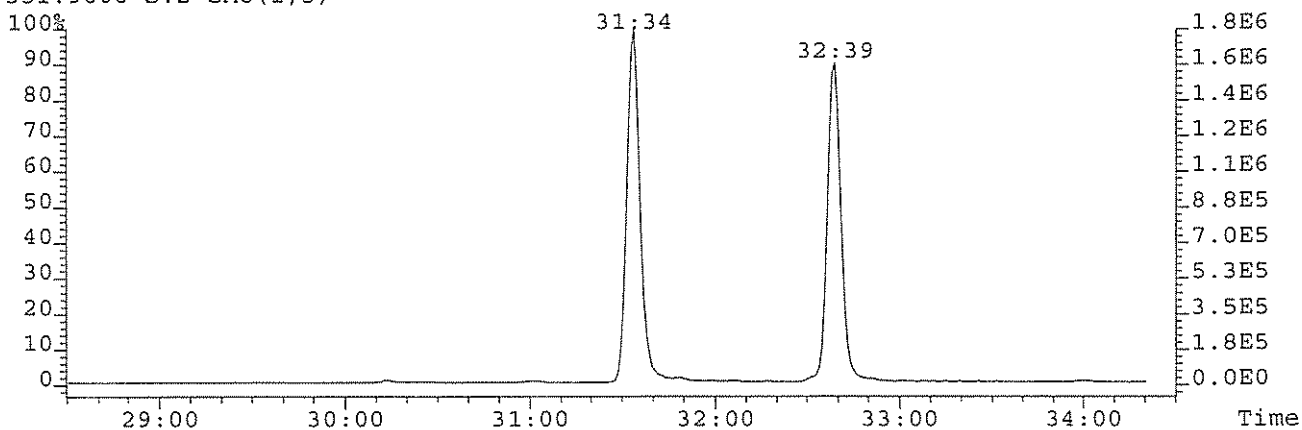
339.8597 S:2 SMO(1,3)



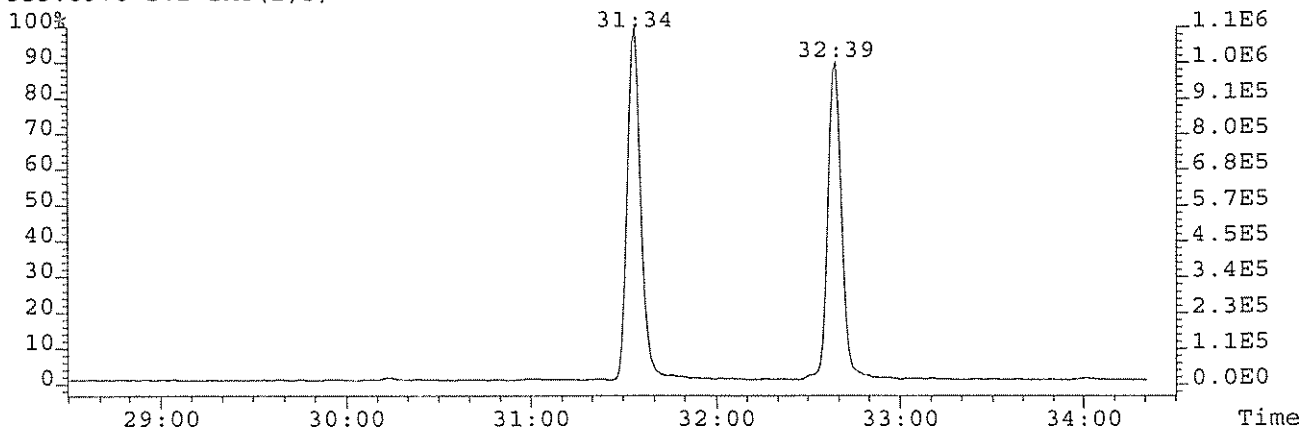
341.8568 S:2 SMO(1,3)



351.9000 S:2 SMO(1,3)

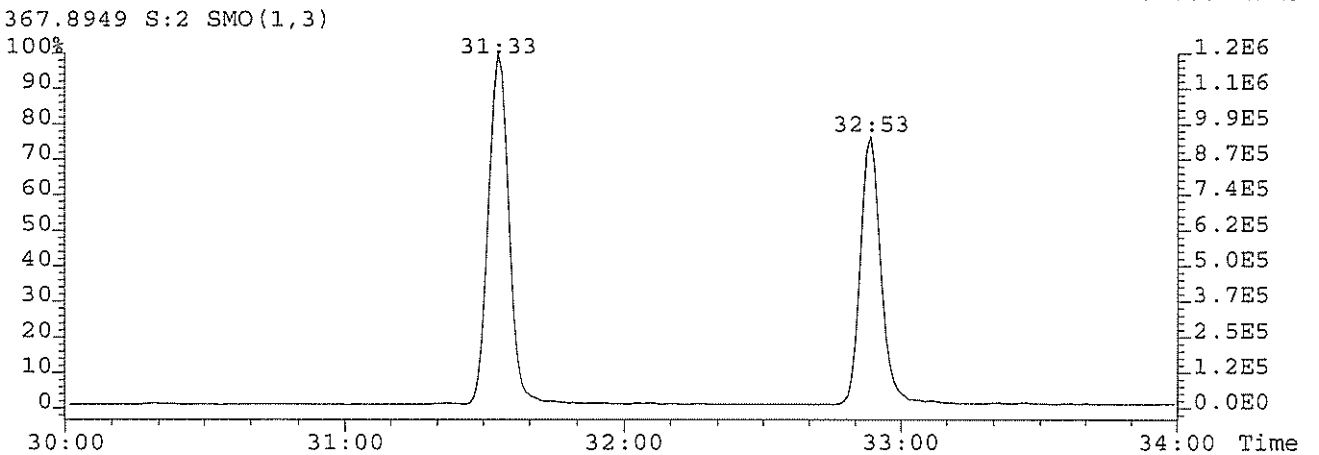
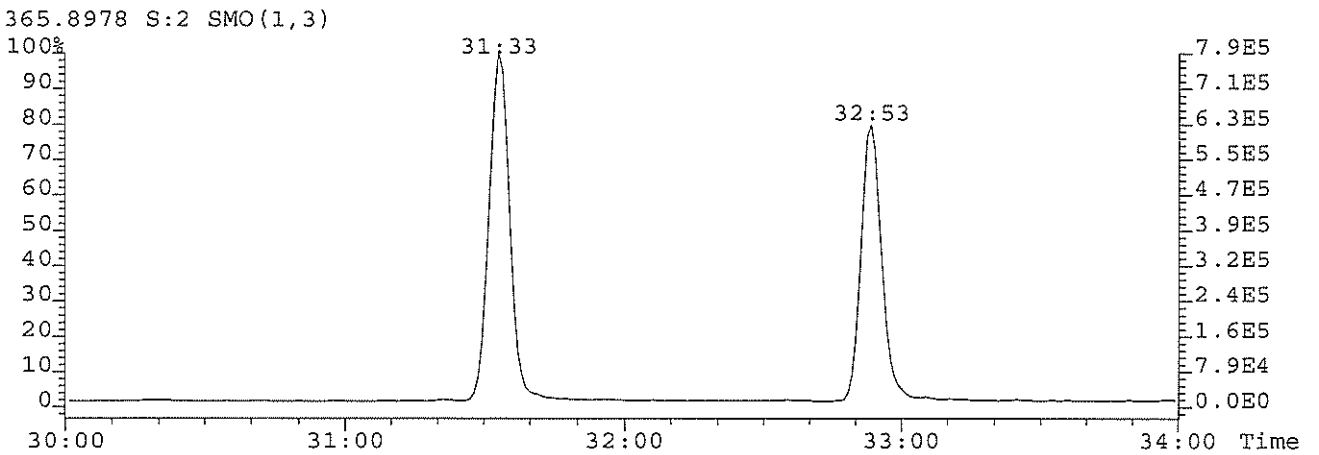
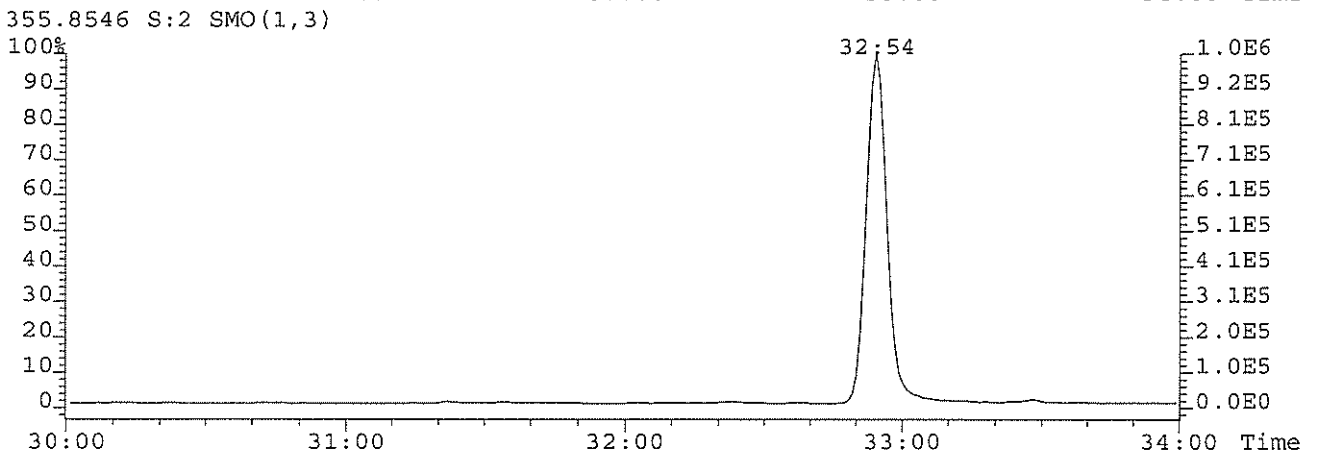
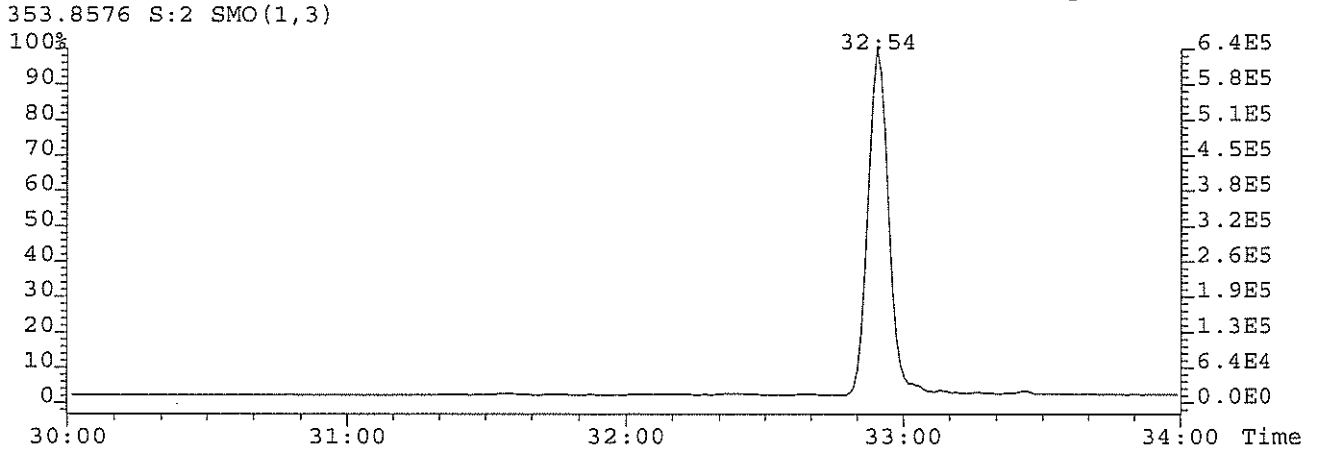


353.8970 S:2 SMO(1,3)



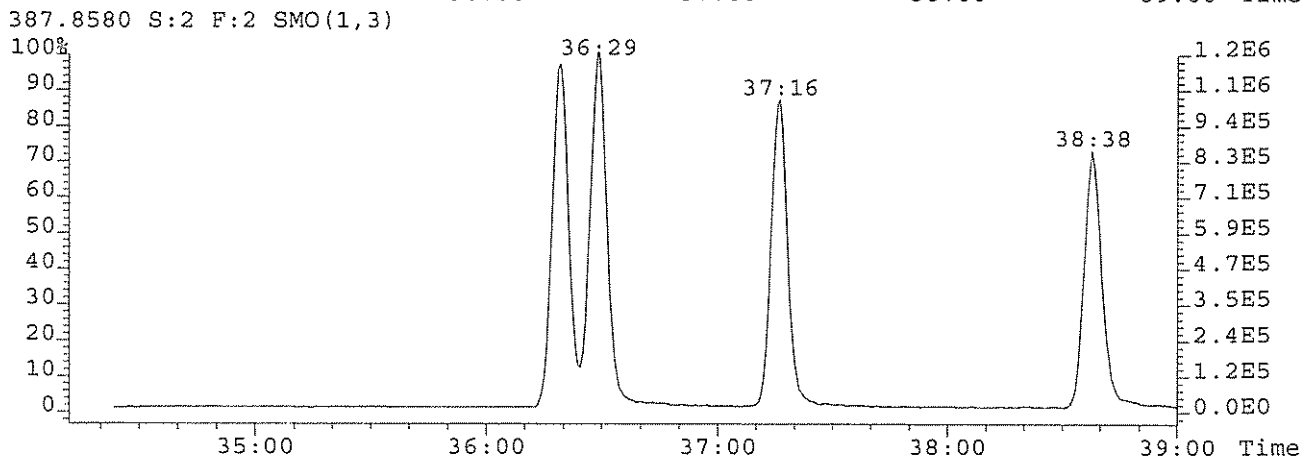
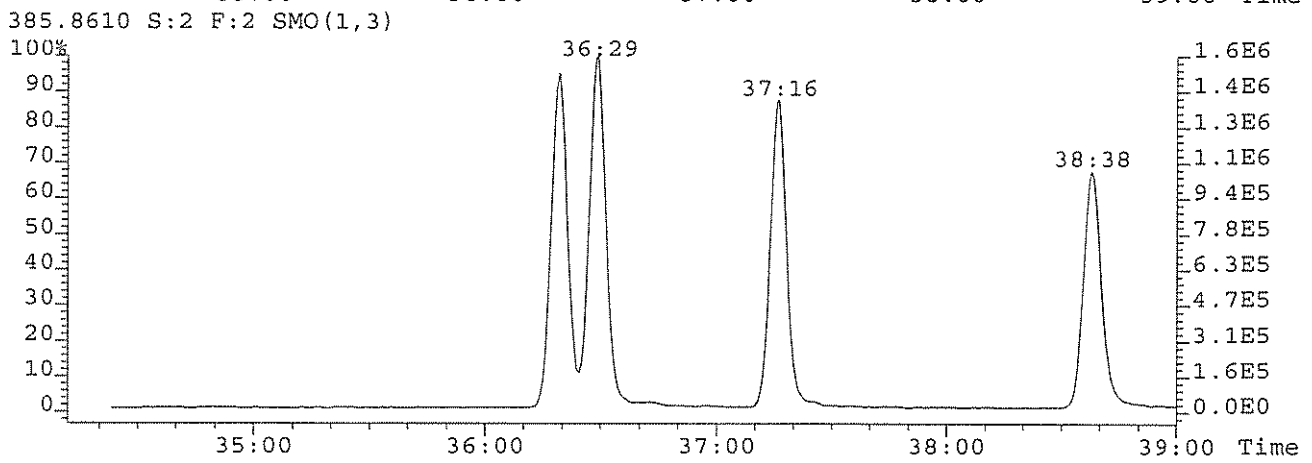
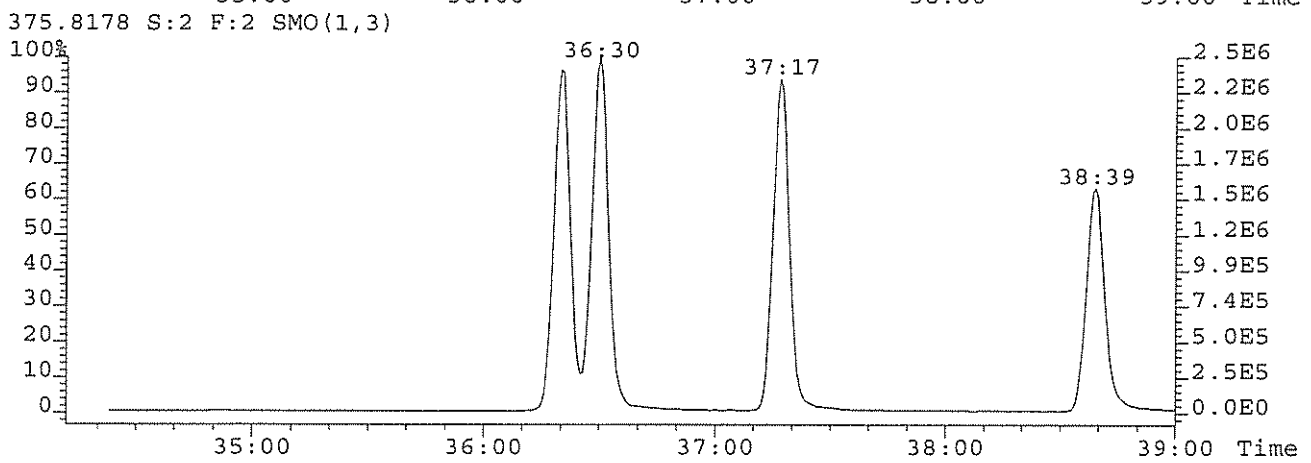
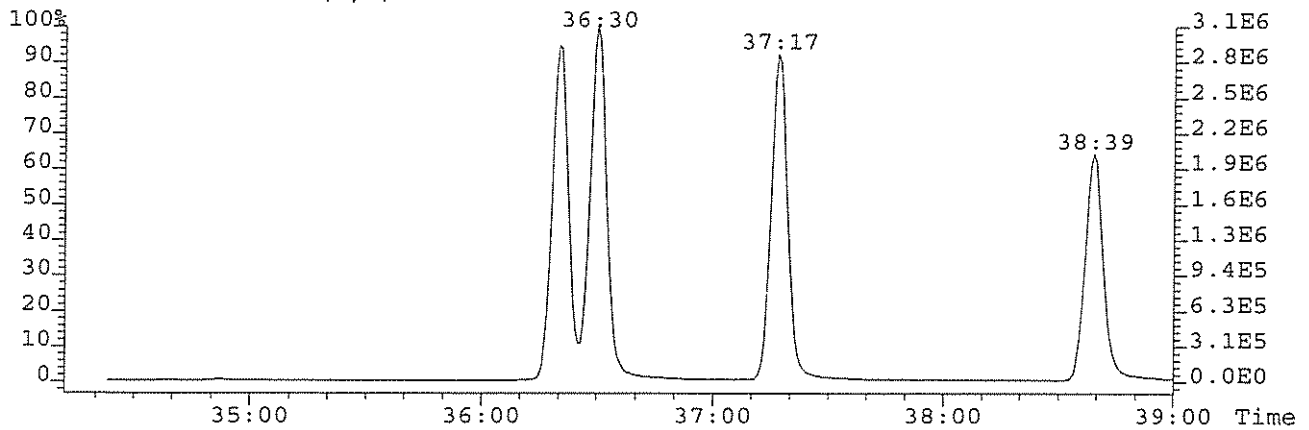
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130716 #1-2009 Acq:16-JUL-2013 12:48:55 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX03



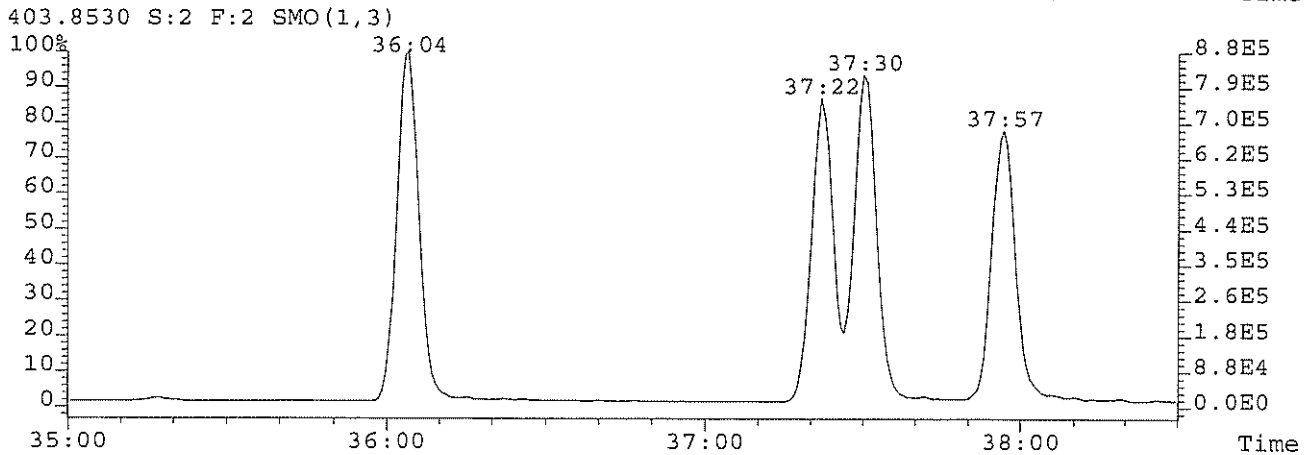
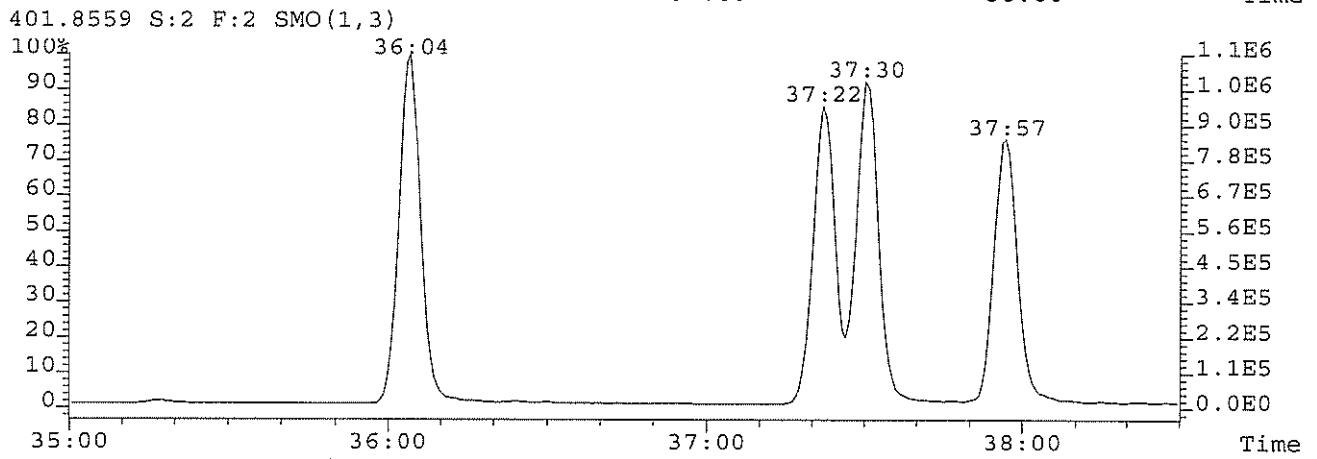
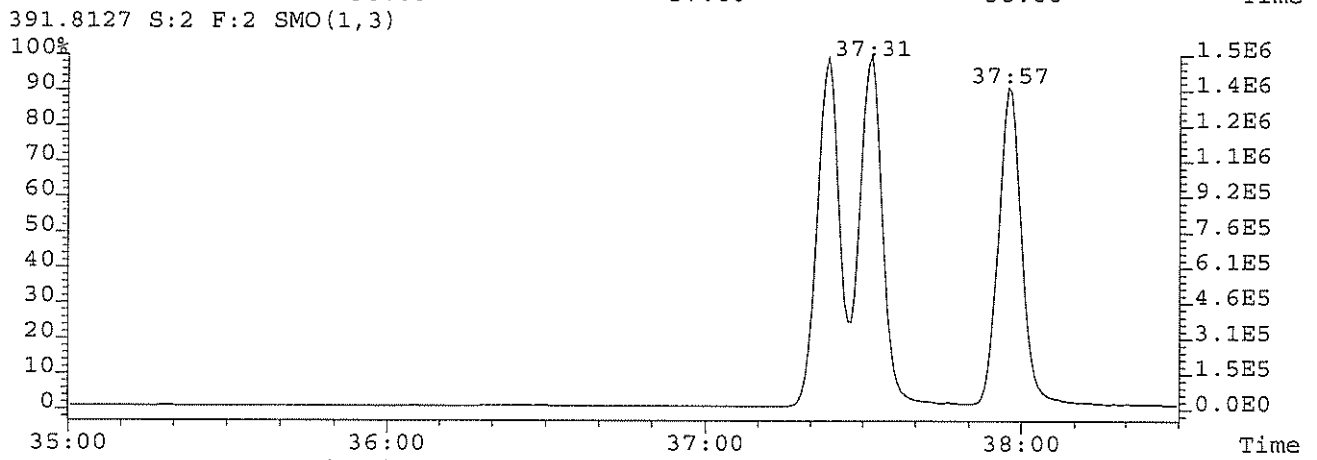
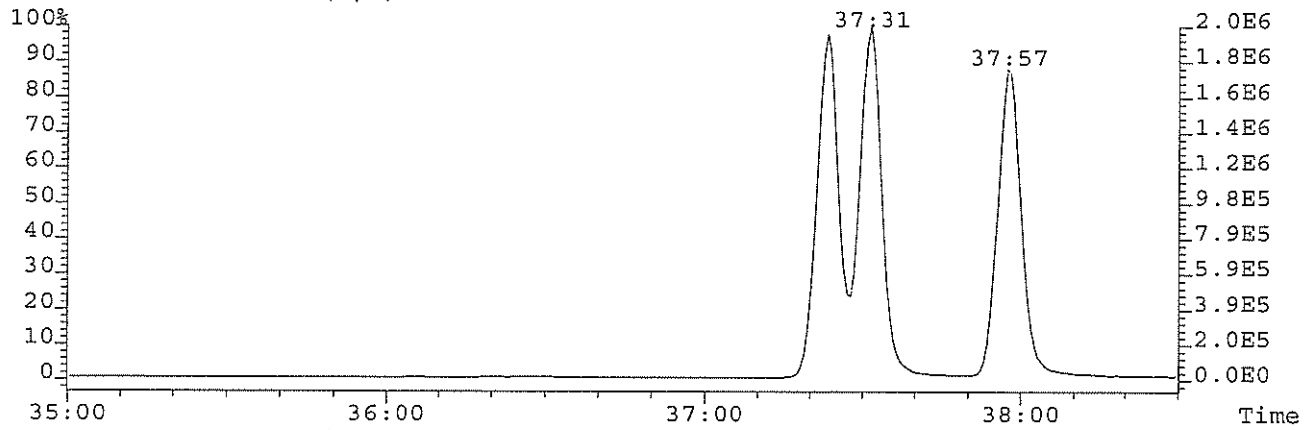
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130716 #1-1955 Acq:16-JUL-2013 12:48:55 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX03  
373.8207 S:2 F:2 SMO(1,3)



PCDFsクロマトグラム (5)  
(HxCDFs)

File:130716 #1-1955 Acq:16-JUL-2013 12:48:55 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:BPX-DXN(4-6DXN) Text:DFP-STD3 Exp:BPX03  
389.8156 S:2 F:2 SMO(1,3)



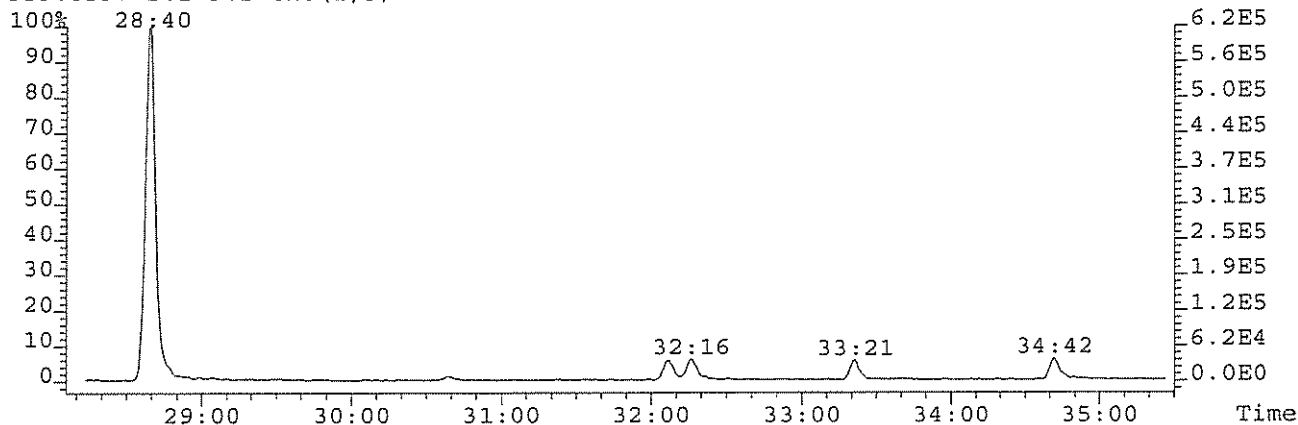
PCDDsクロマトグラム (6)  
(HxCDDs)



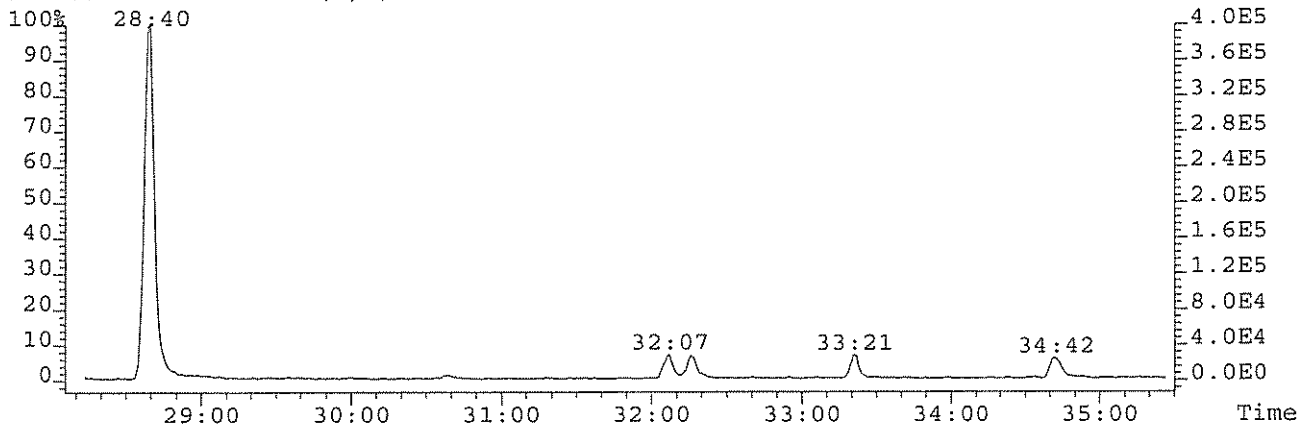
標準物質	
測定日	平成25年7月11日
測定物質	2,3,4,7,8-PeCDF, 1,2,3,7,8,9-HxCDF HpCDDs/DFs, OCDD/DFの同族体及び 2,3,7,8-位塩素置換異性体, Non-ortho PCB

File:130711 #1-648 Acq:11-JUL-2013 11:56:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

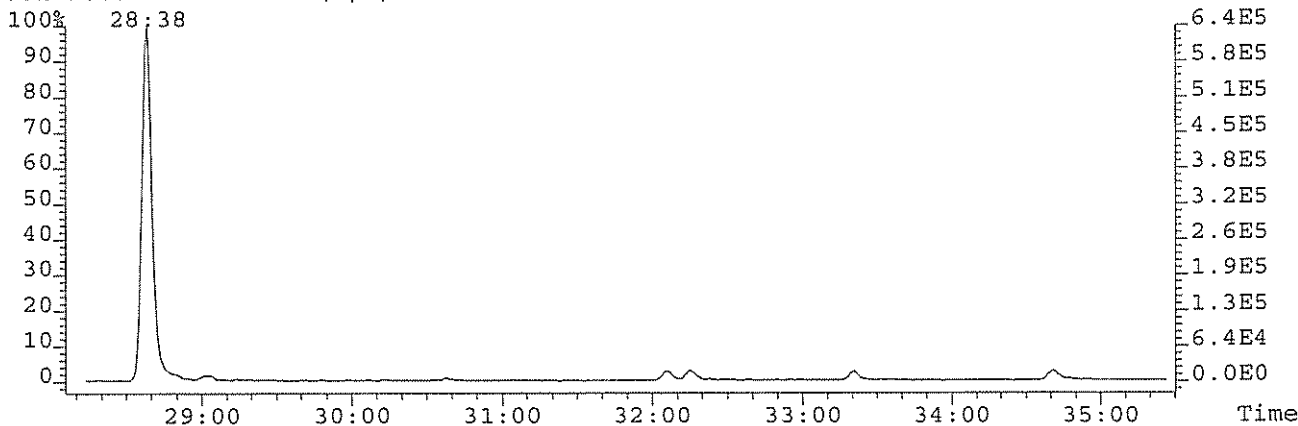
339.8597 S:2 F:2 SMO(1,3)



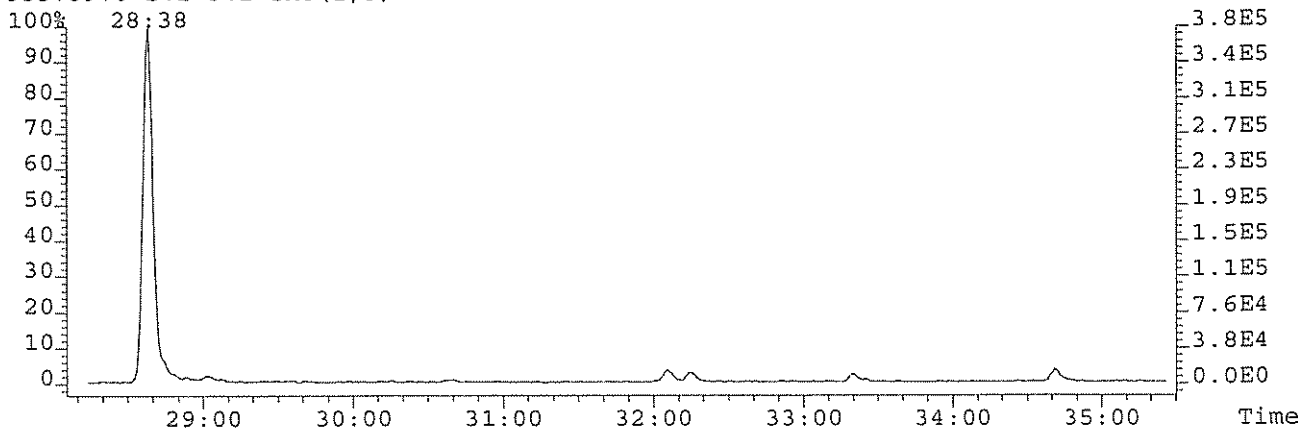
341.8568 S:2 F:2 SMO(1,3)



351.9000 S:2 F:2 SMO(1,3)

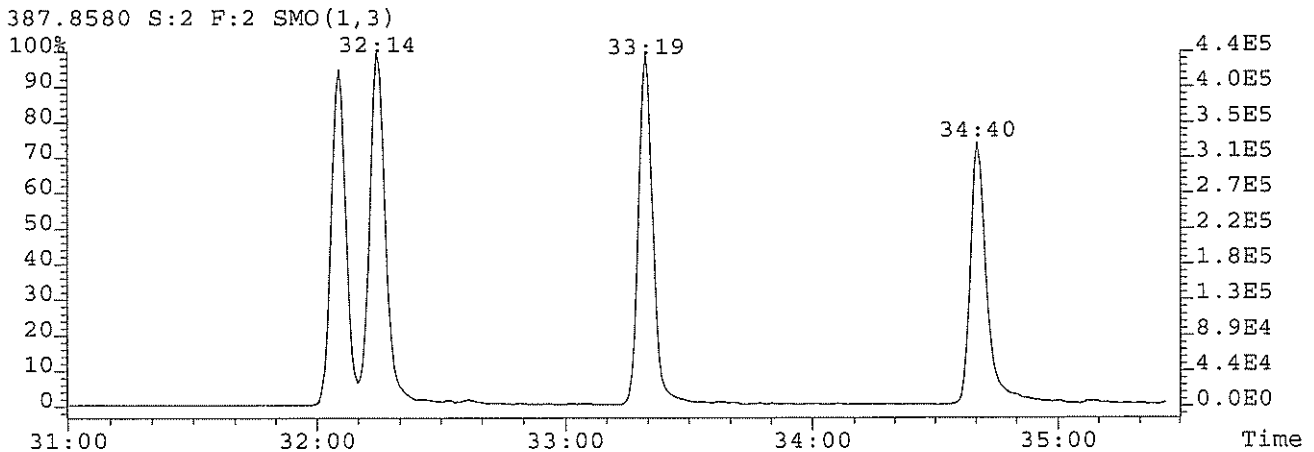
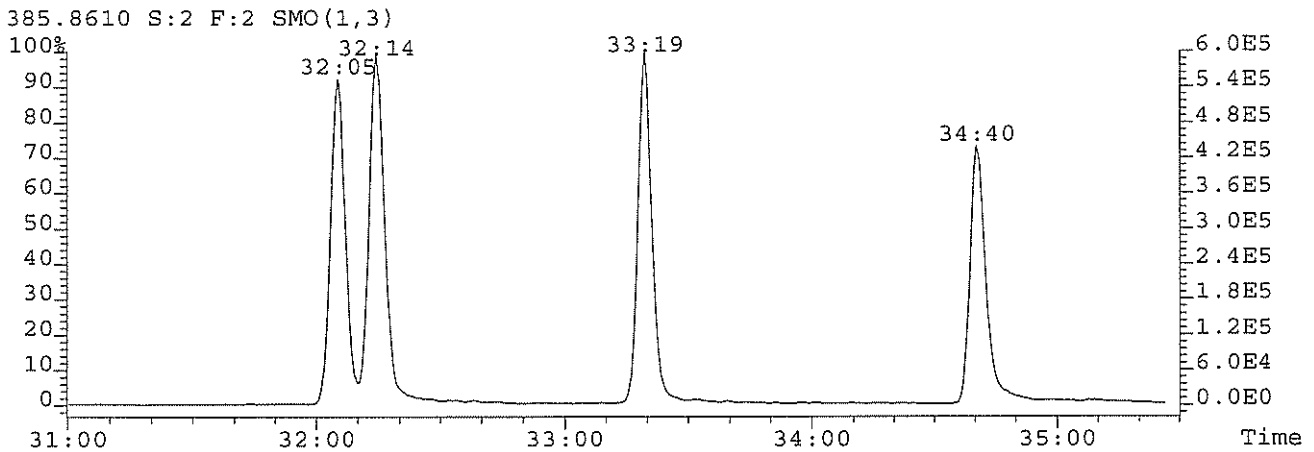
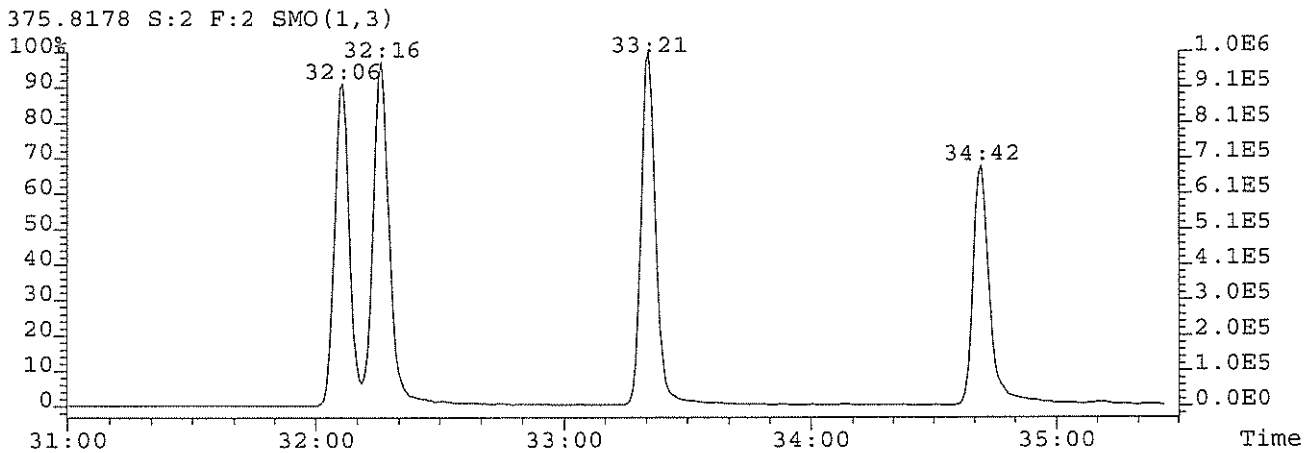
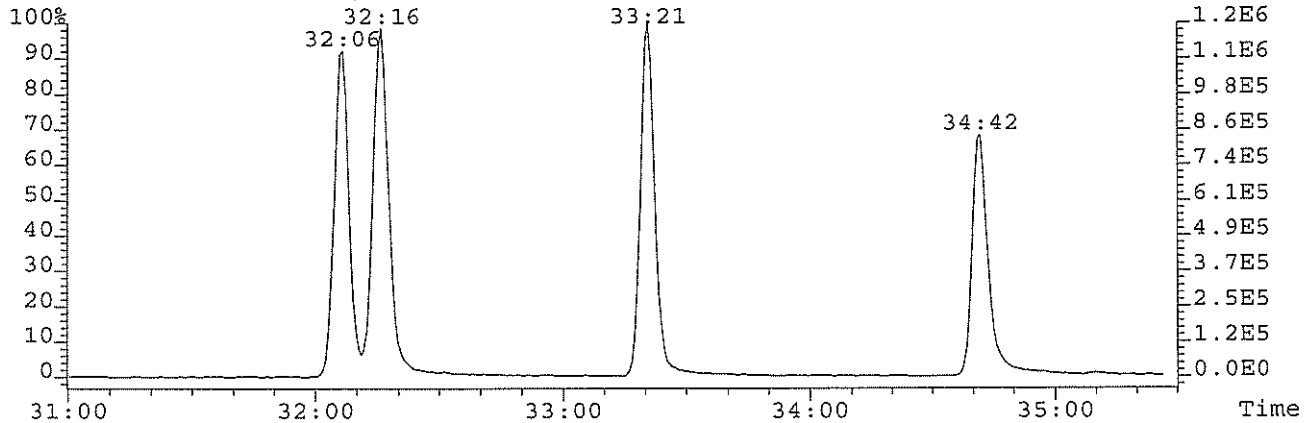


353.8970 S:2 F:2 SMO(1,3)



PeCDFsクロマトグラム (7)  
(23478-PeCDF)

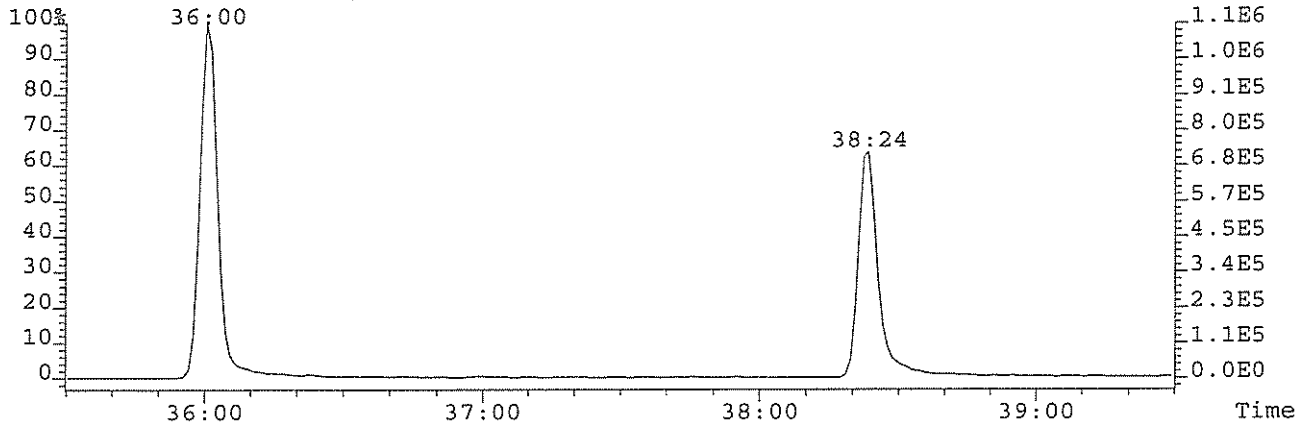
File:130711 #1-648 Acq:11-JUL-2013 11:56:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22  
373.8207 S:2 F:2 SMO(1,3)



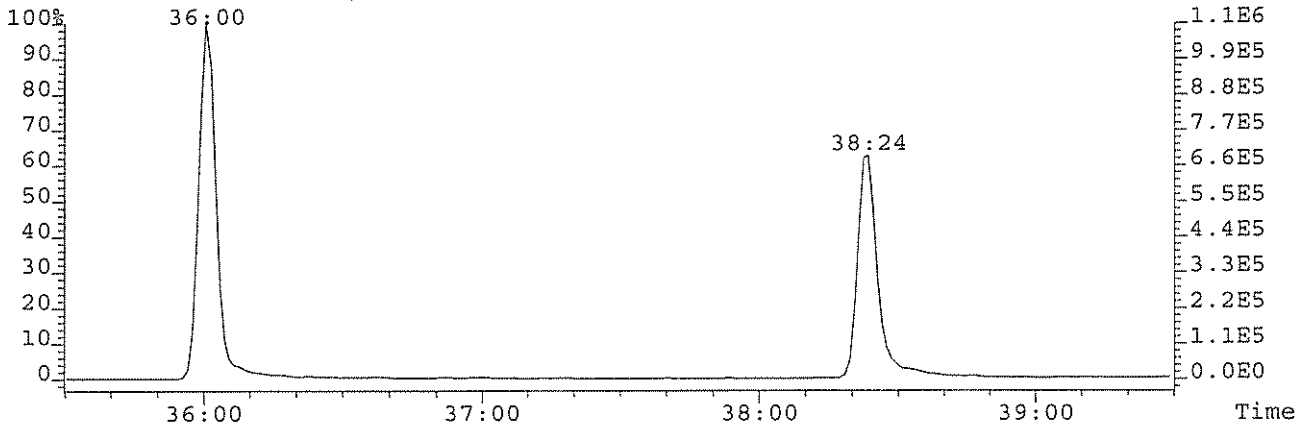
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130711 #1-562 Acq:11-JUL-2013 11:56:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

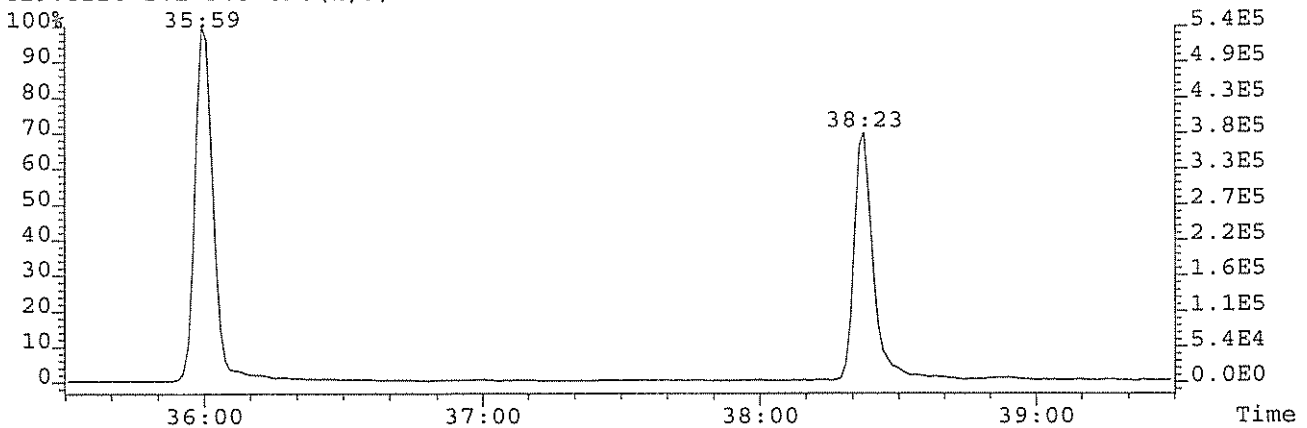
407.7818 S:2 F:3 SMO(1,3)



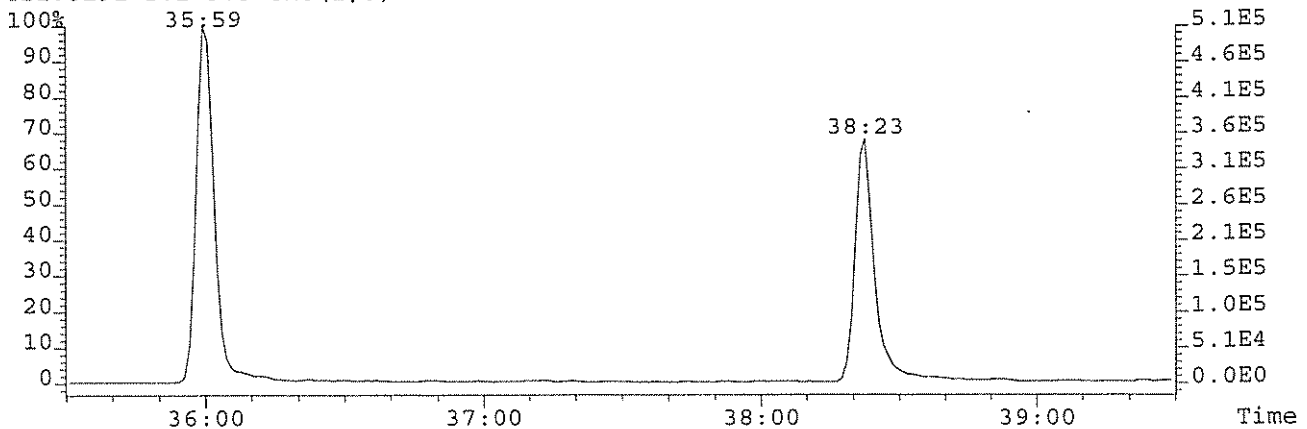
409.7788 S:2 F:3 SMO(1,3)



419.8220 S:2 F:3 SMO(1,3)

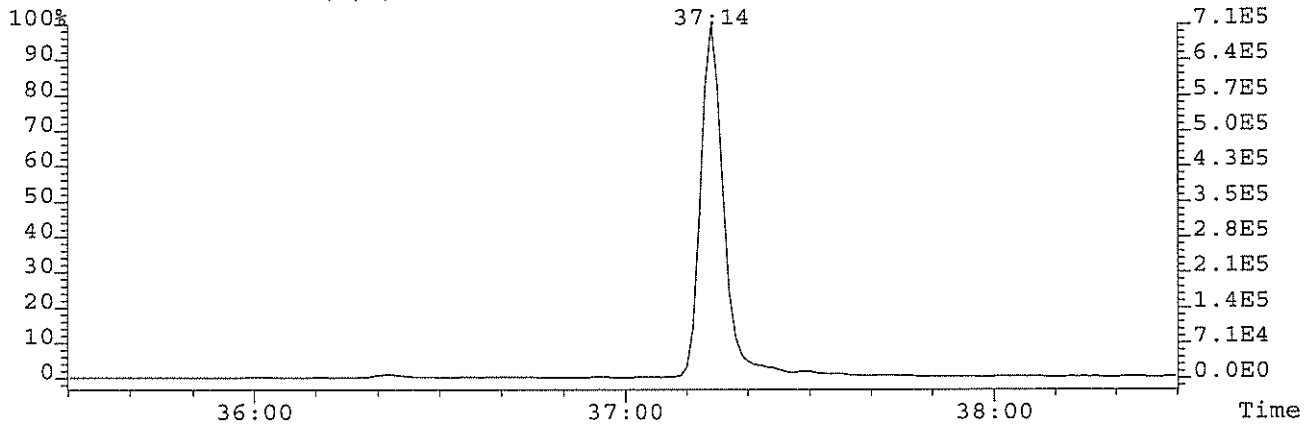


421.8191 S:2 F:3 SMO(1,3)

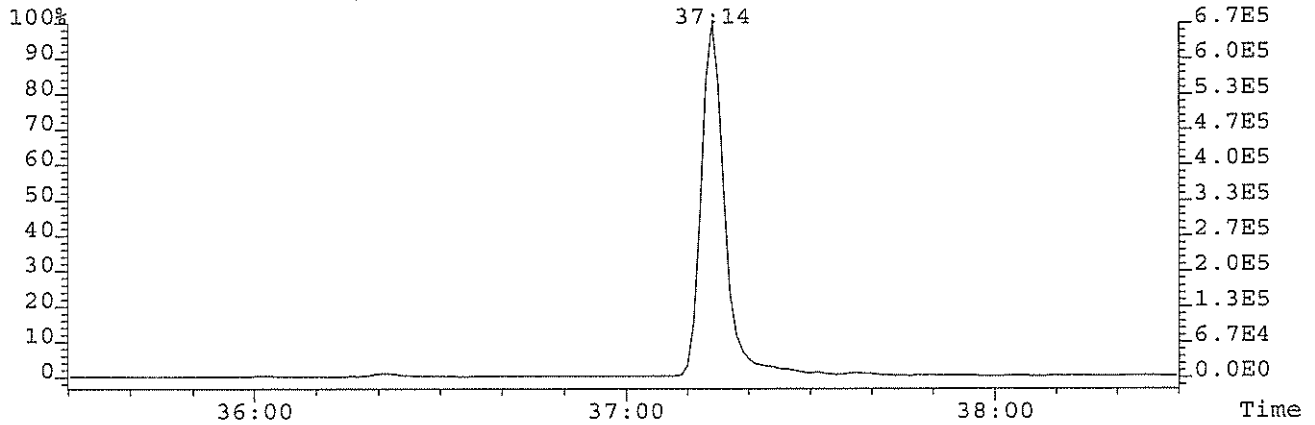


PCDFsクロマトグラム (9)  
(HpCDFs)

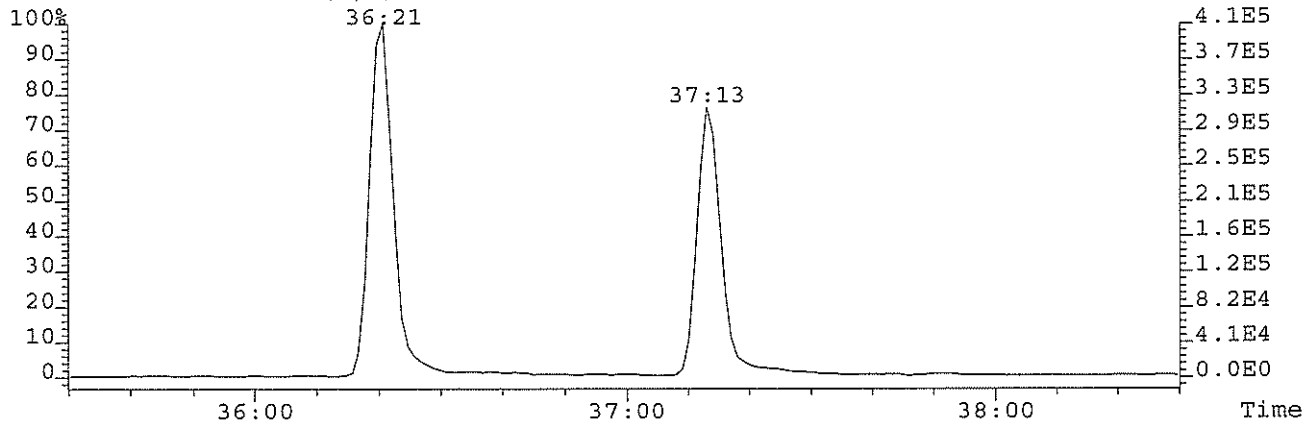
File:130711 #1-562 Acq:11-JUL-2013 11:56:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22  
423.7767 S:2 F:3 SMO(1,3)



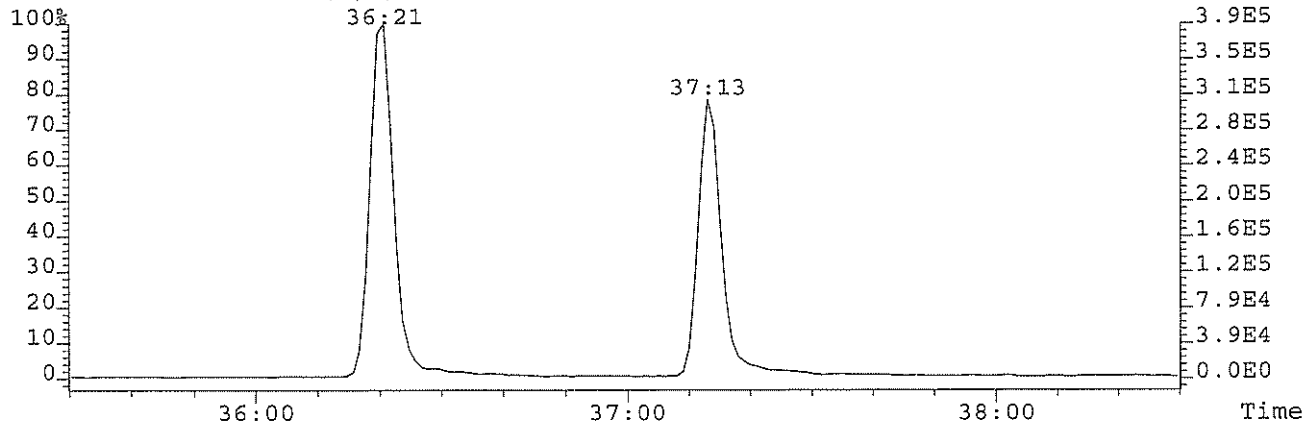
425.7737 S:2 F:3 SMO(1,3)



435.8169 S:2 F:3 SMO(1,3)



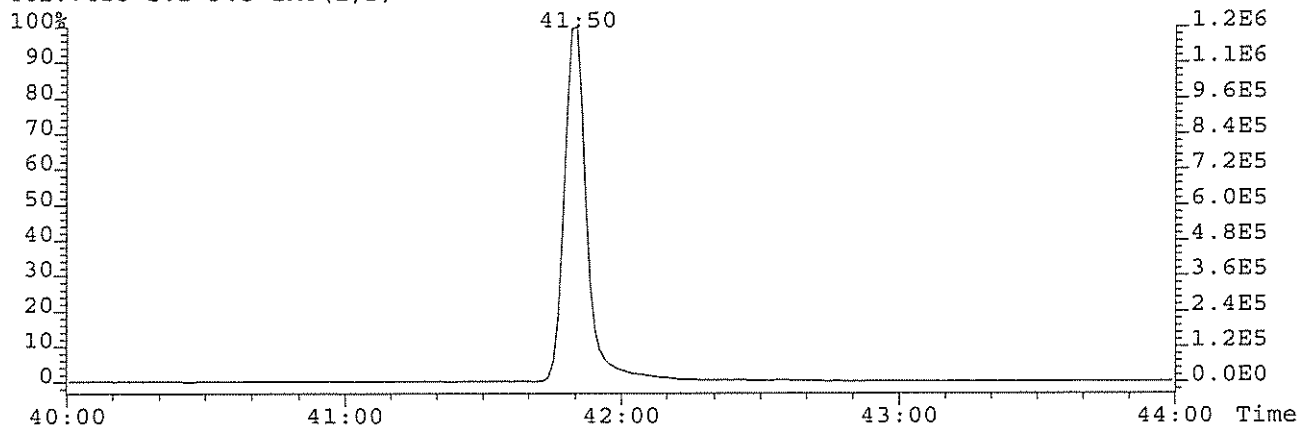
437.8140 S:2 F:3 SMO(1,3)



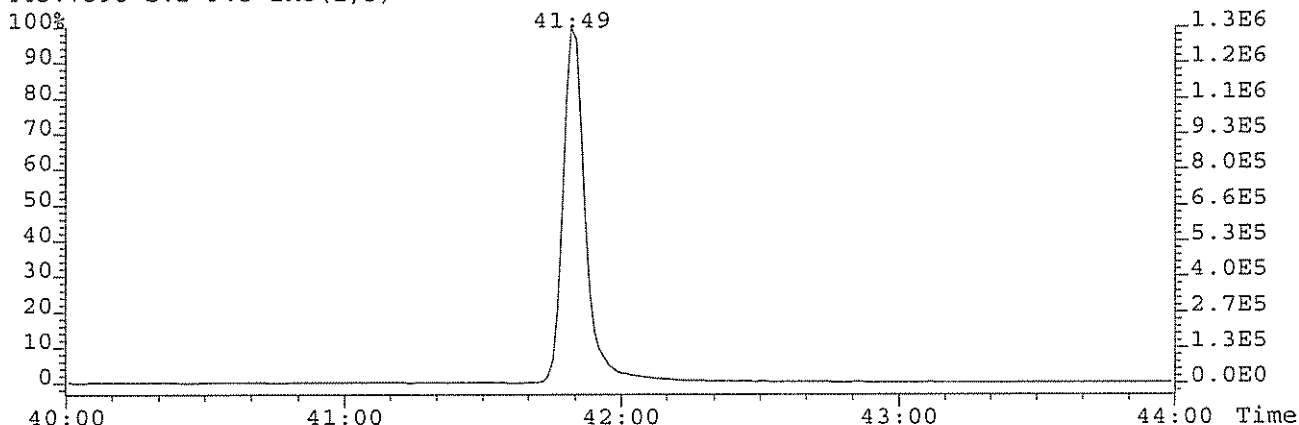
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130711 #1-562 Acq:11-JUL-2013 11:56:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

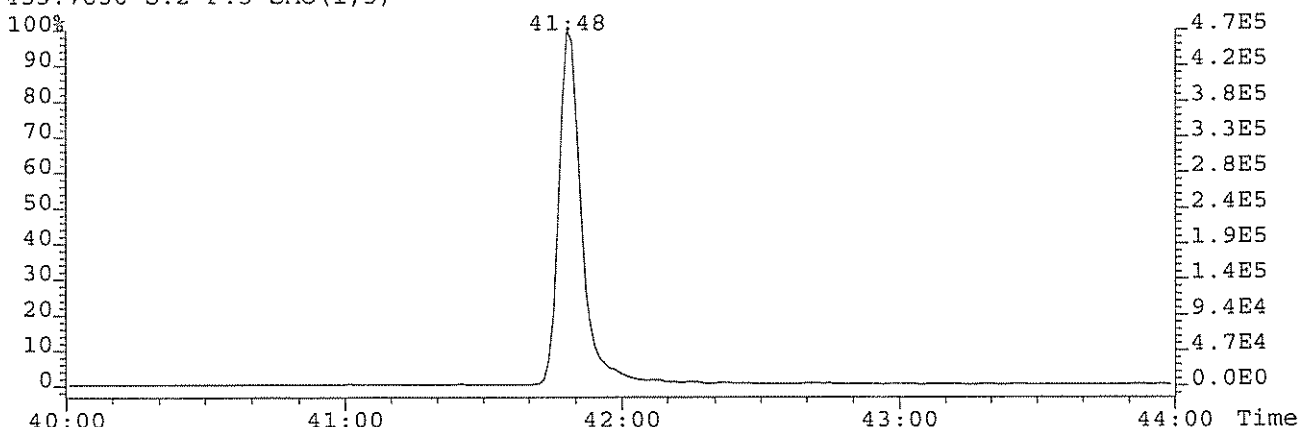
441.7428 S:2 F:3 SMO(1,3)



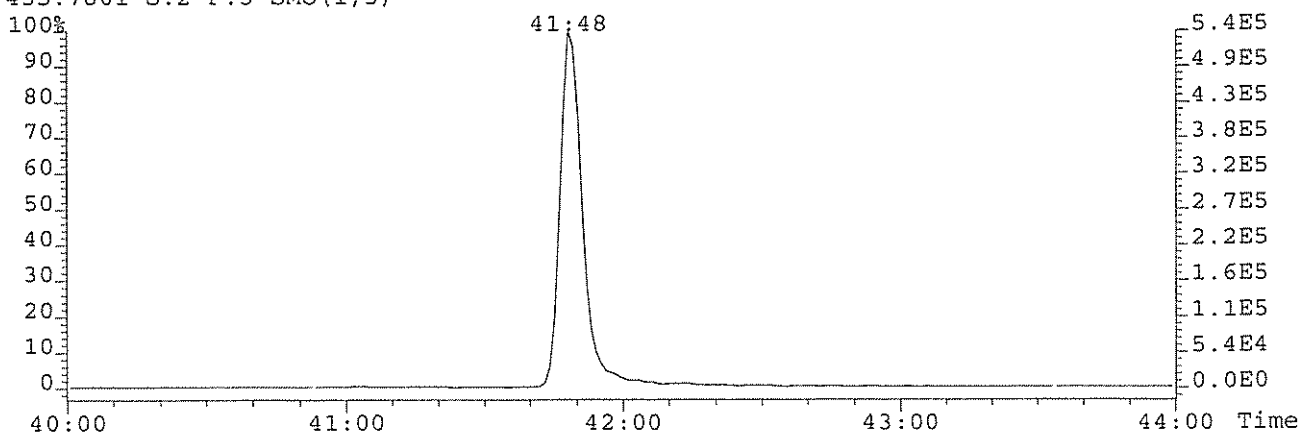
443.7398 S:2 F:3 SMO(1,3)



453.7830 S:2 F:3 SMO(1,3)

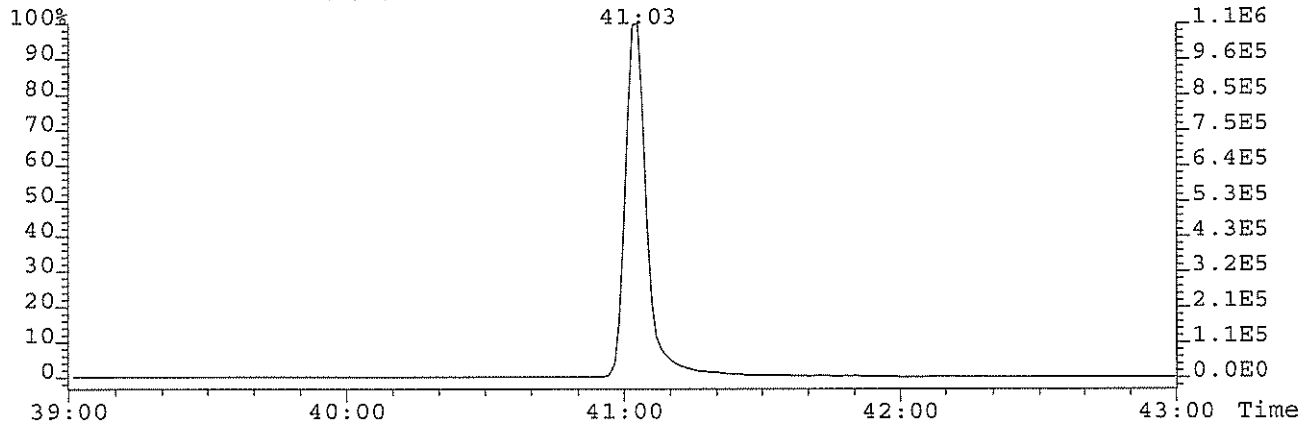


455.7801 S:2 F:3 SMO(1,3)

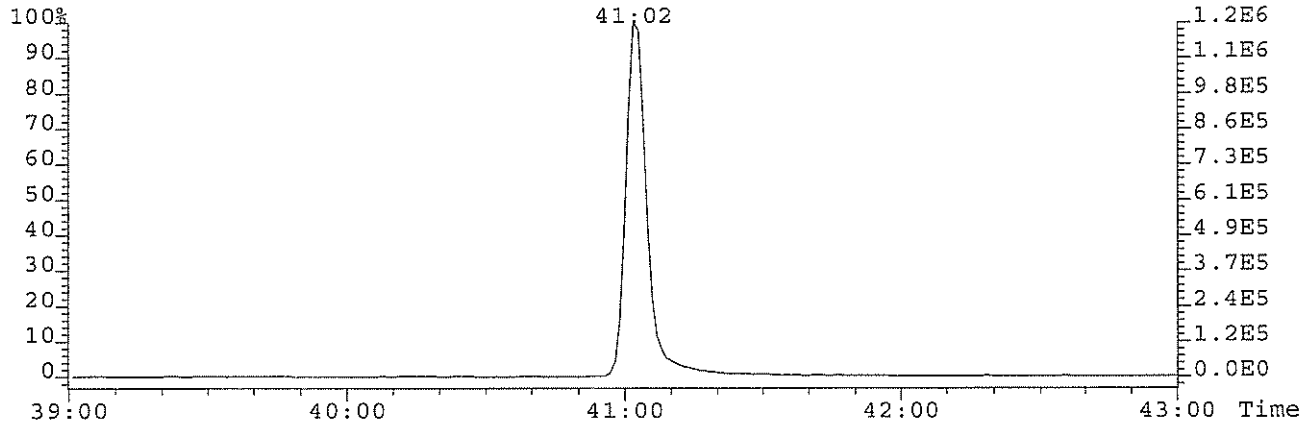


PCDFsクロマトグラム (11)  
(OCDF)

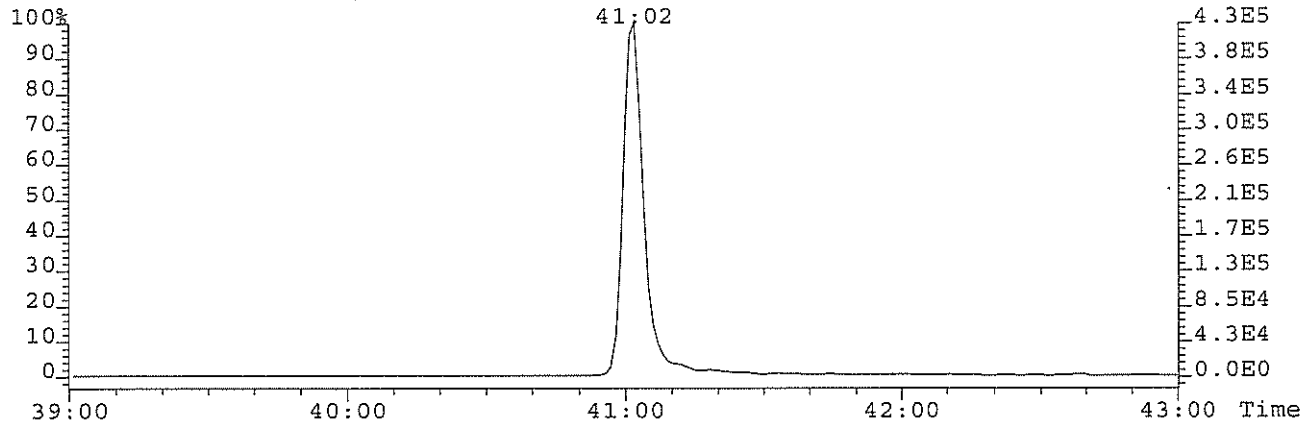
File:130711 #1-562 Acq:11-JUL-2013 11:56:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22  
457.7377 S:2 F:3 SMO(1,3)



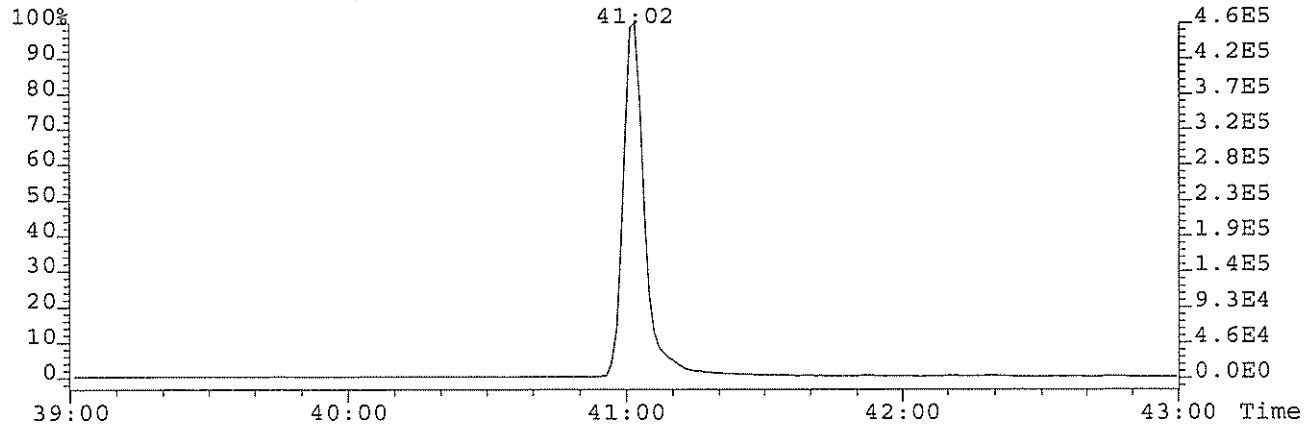
459.7348 S:2 F:3 SMO(1,3)



469.7780 S:2 F:3 SMO(1,3)



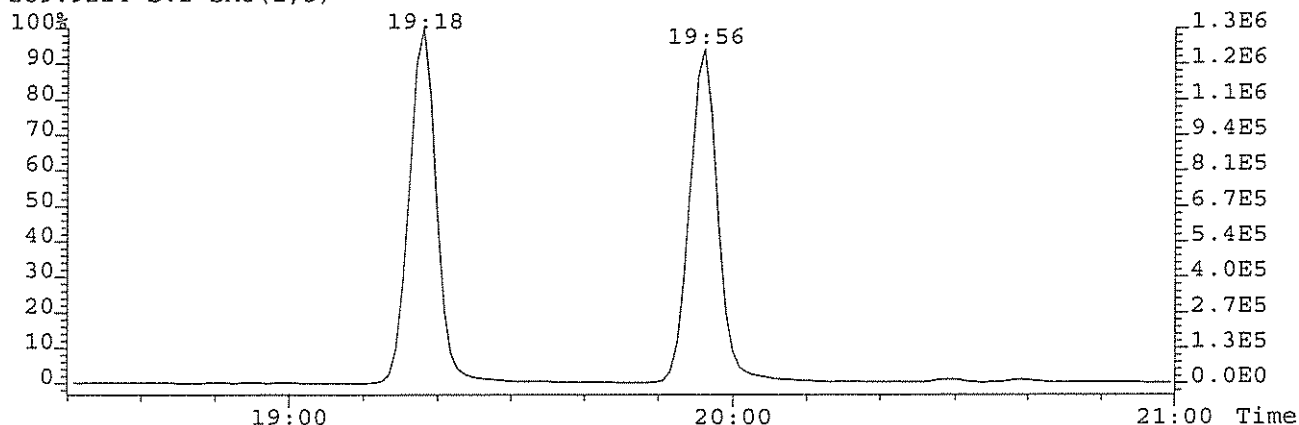
471.7750 S:2 F:3 SMO(1,3)



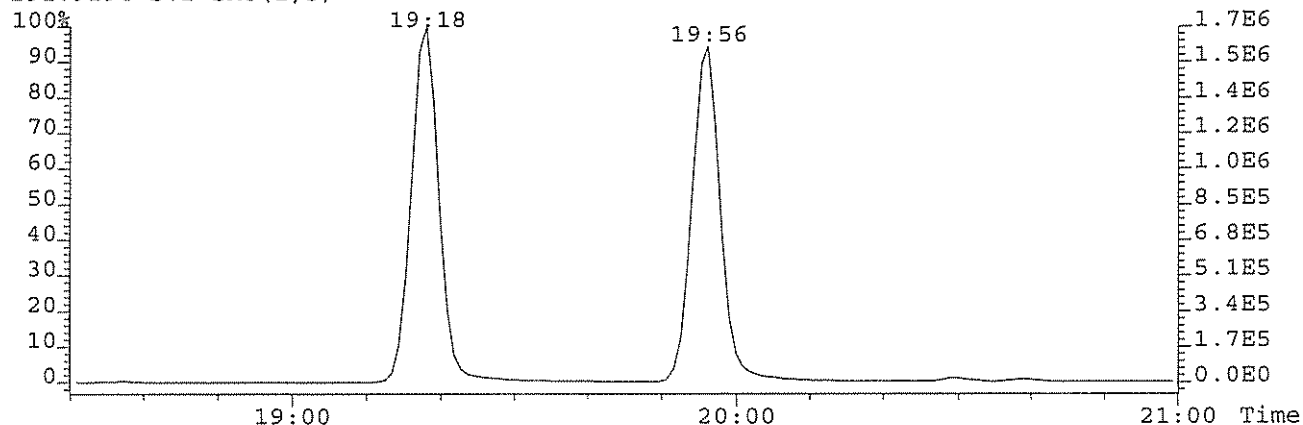
PCDDsクロマトグラム (12)  
(OCDD)

File:130711 #1-1430 Acq:11-JUL-2013 11:56:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

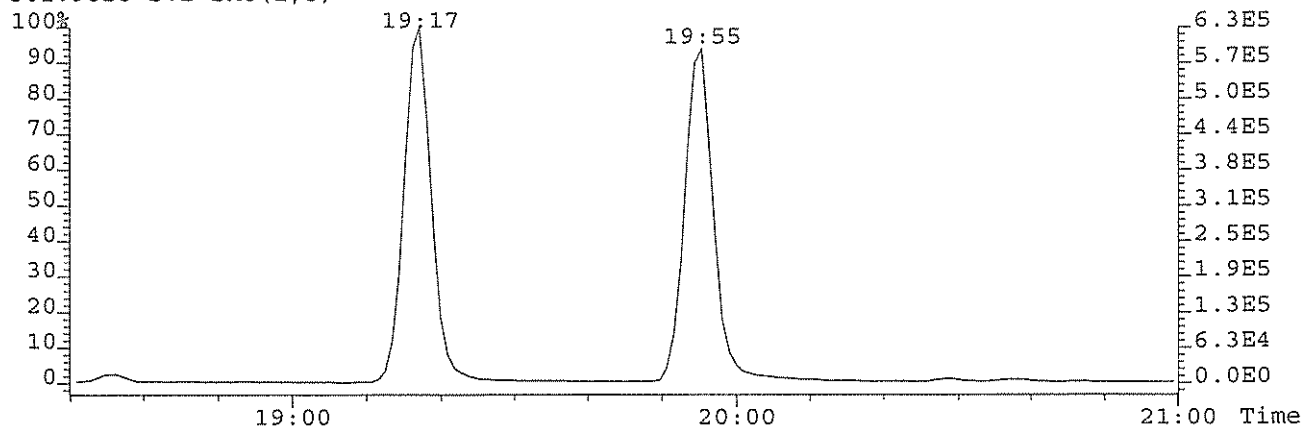
289.9224 S:2 SMO(1,3)



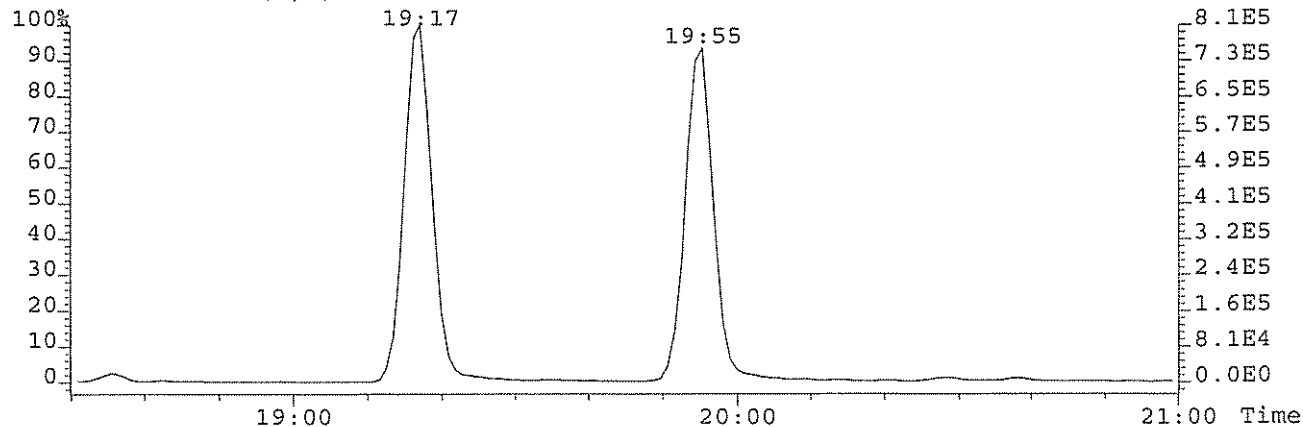
291.9194 S:2 SMO(1,3)



301.9626 S:2 SMO(1,3)



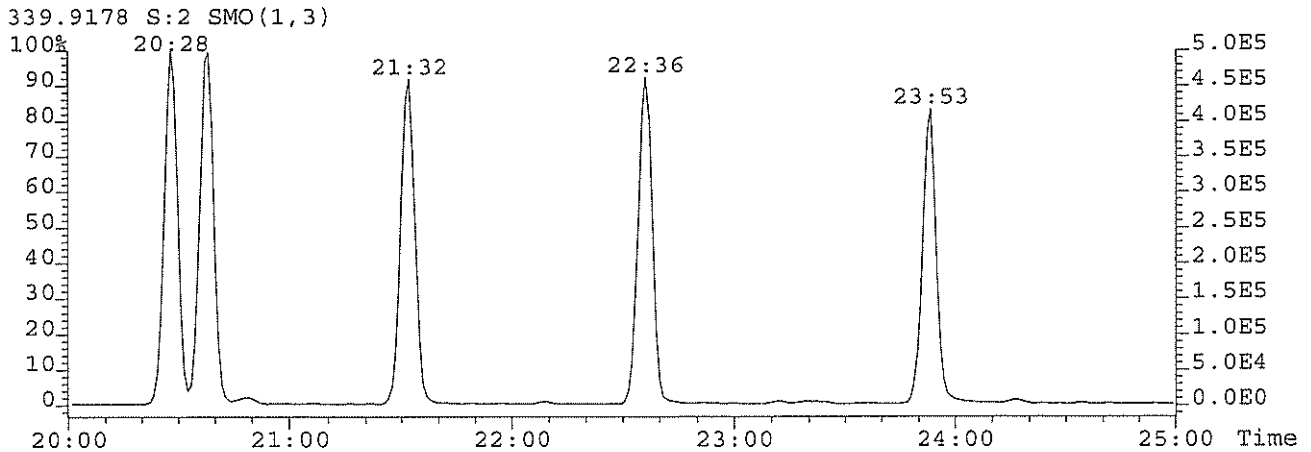
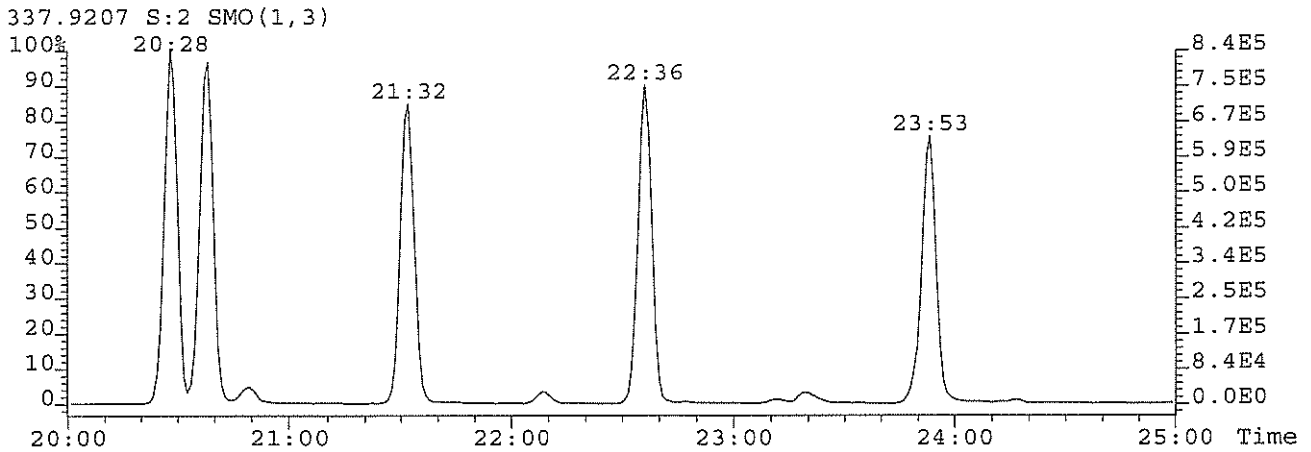
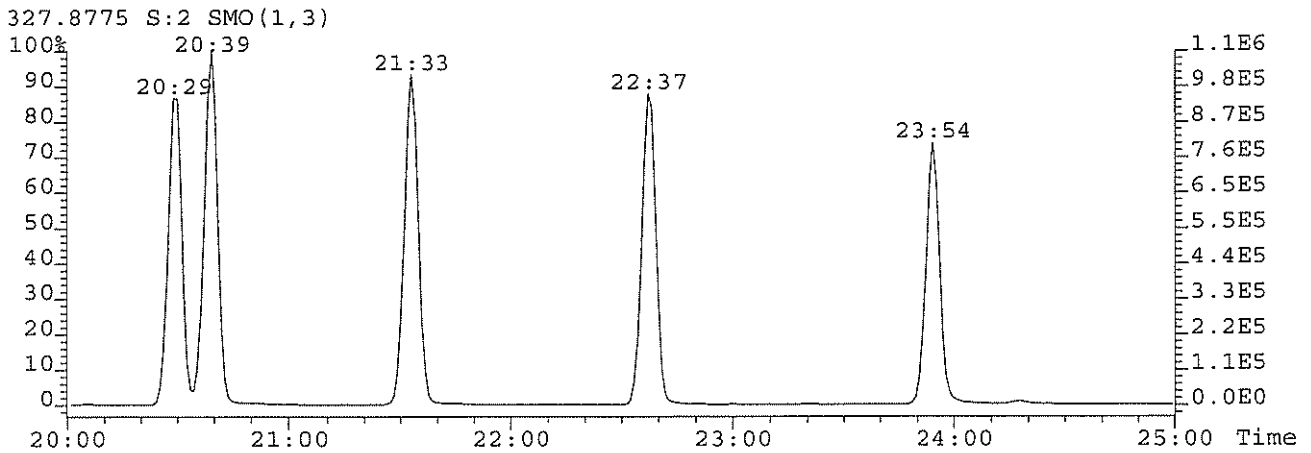
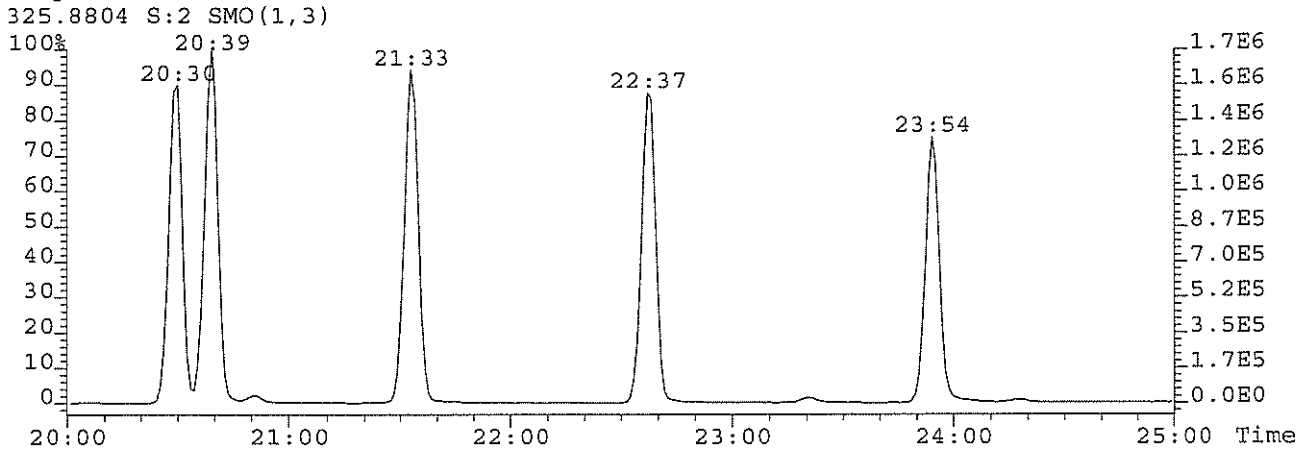
303.9597 S:2 SMO(1,3)



DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

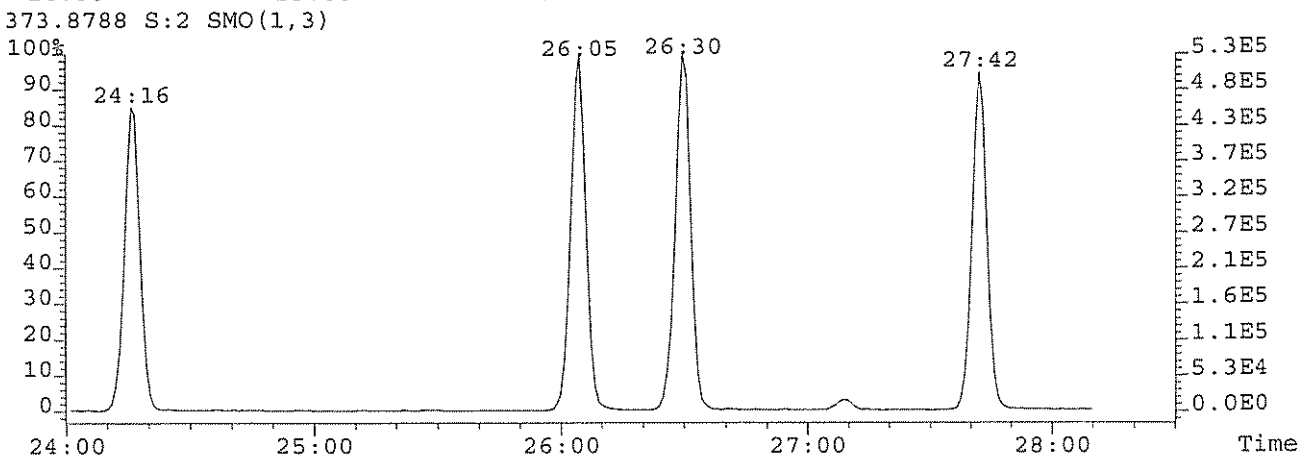
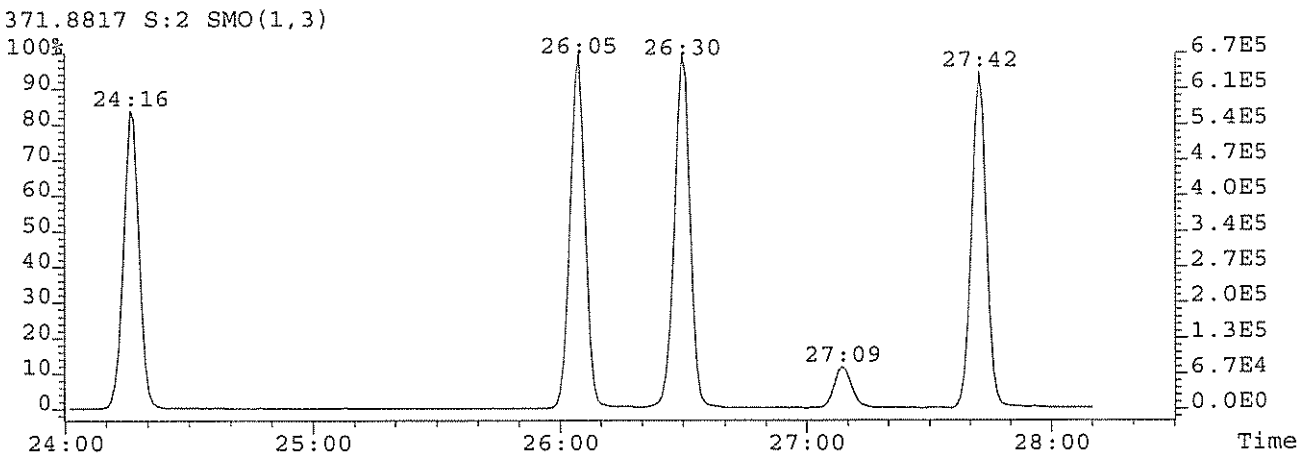
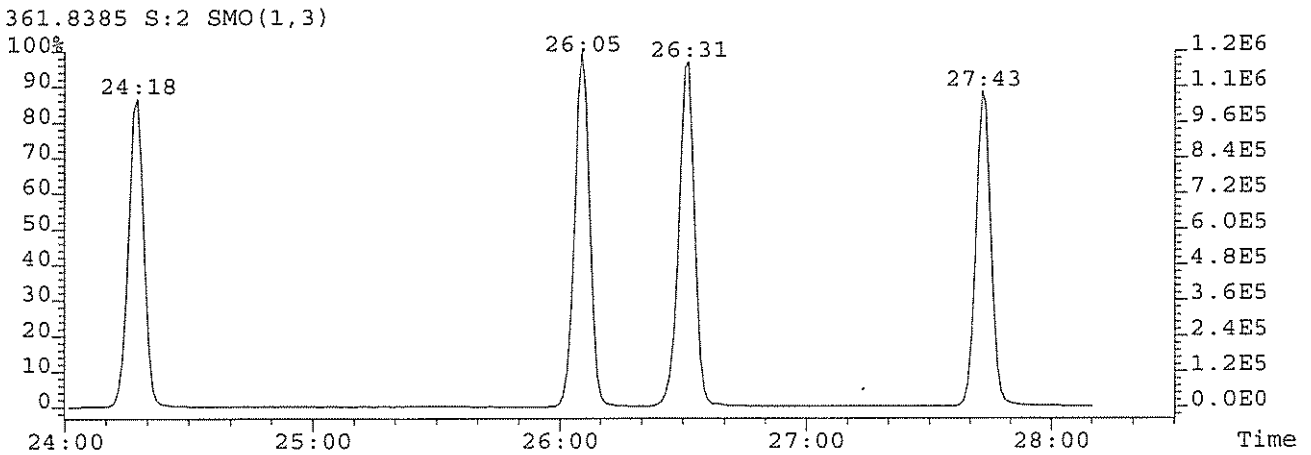
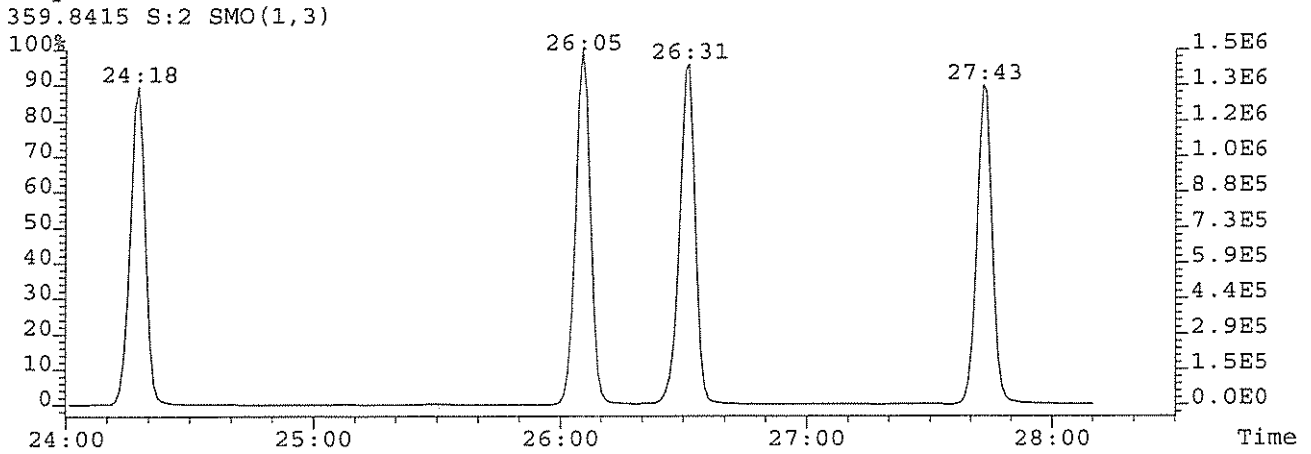


File:130711 #1-1430 Acq:11-JUL-2013 11:56:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22



DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

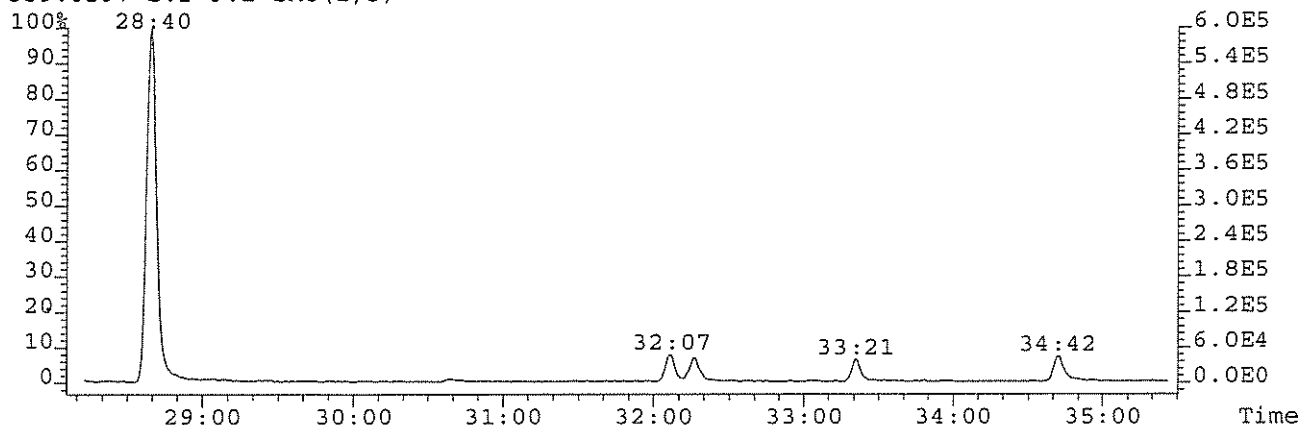
File:130711 #1-1430 Acq:11-JUL-2013 11:56:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22



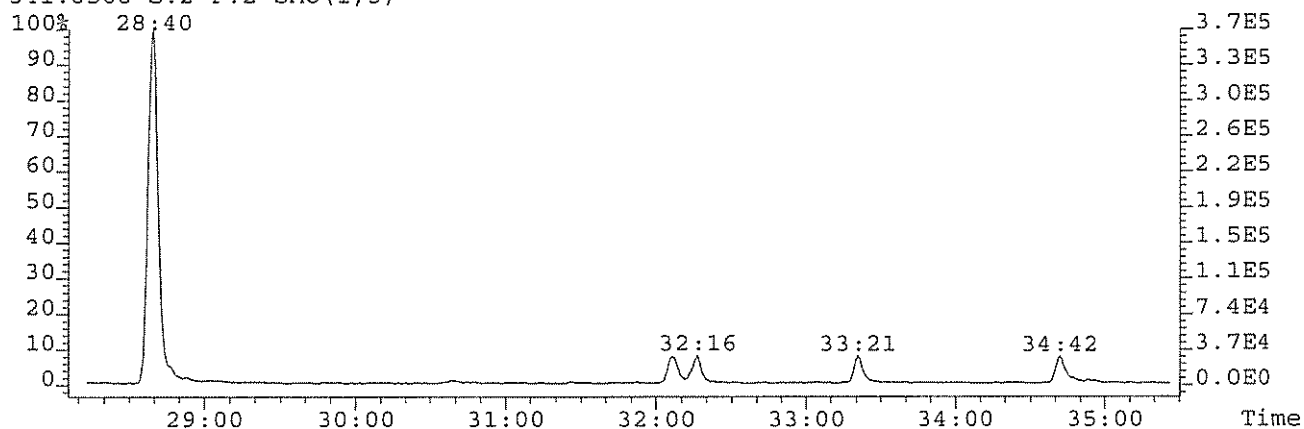
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

標準物質	
測定日	平成25年7月13日
測定物質	2,3,4,7,8-PeCDF, 1,2,3,7,8,9-HxCDF HpCDDs/DFs, OCDD/DFの同族体及び 2,3,7,8-位塩素置換異性体, Non-ortho PCB

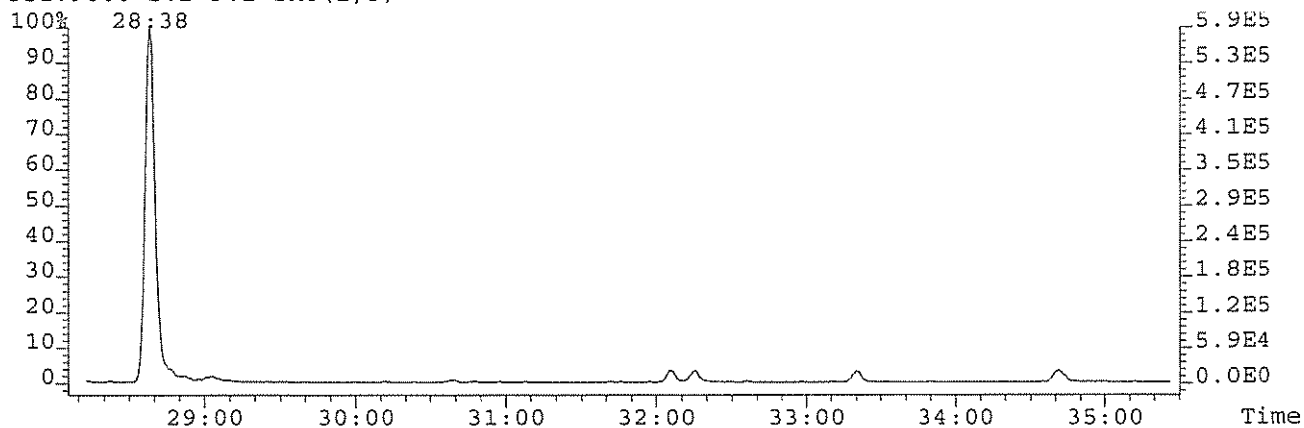
File:130713 #1-649 Acq:13-JUL-2013 13:06:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22  
339.8597 S:2 F:2 SMO(1,3)



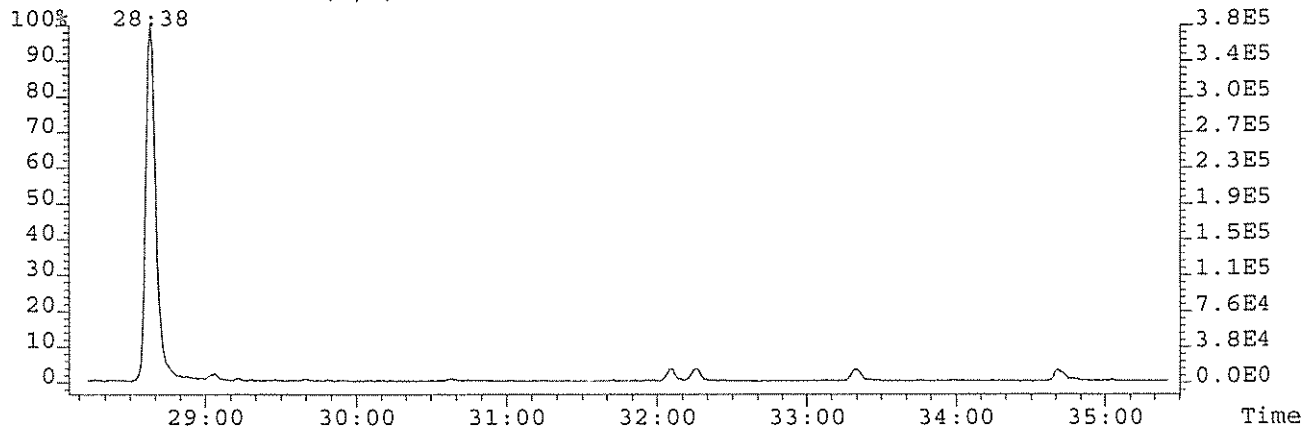
341.8568 S:2 F:2 SMO(1,3)



351.9000 S:2 F:2 SMO(1,3)

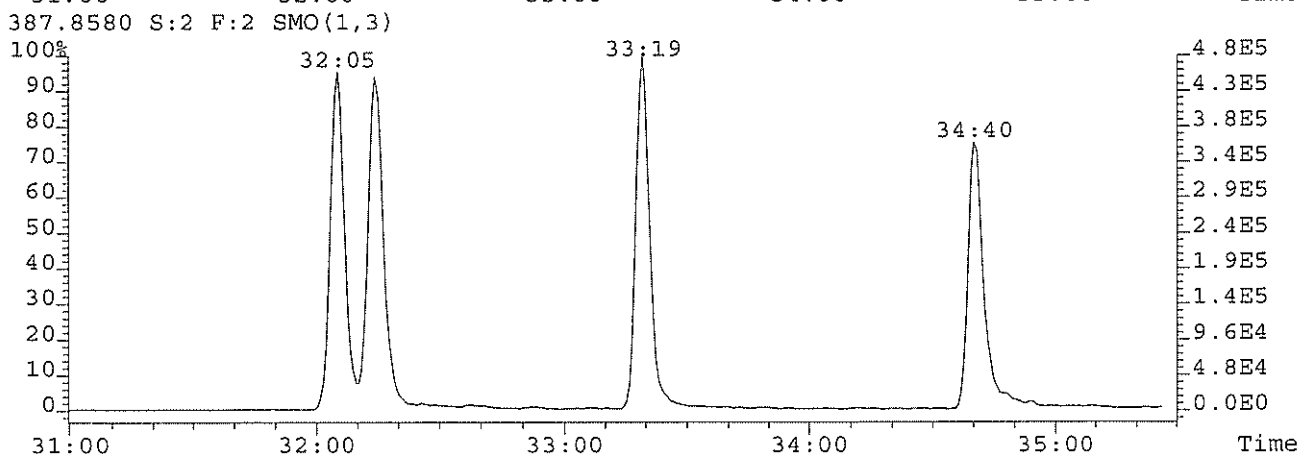
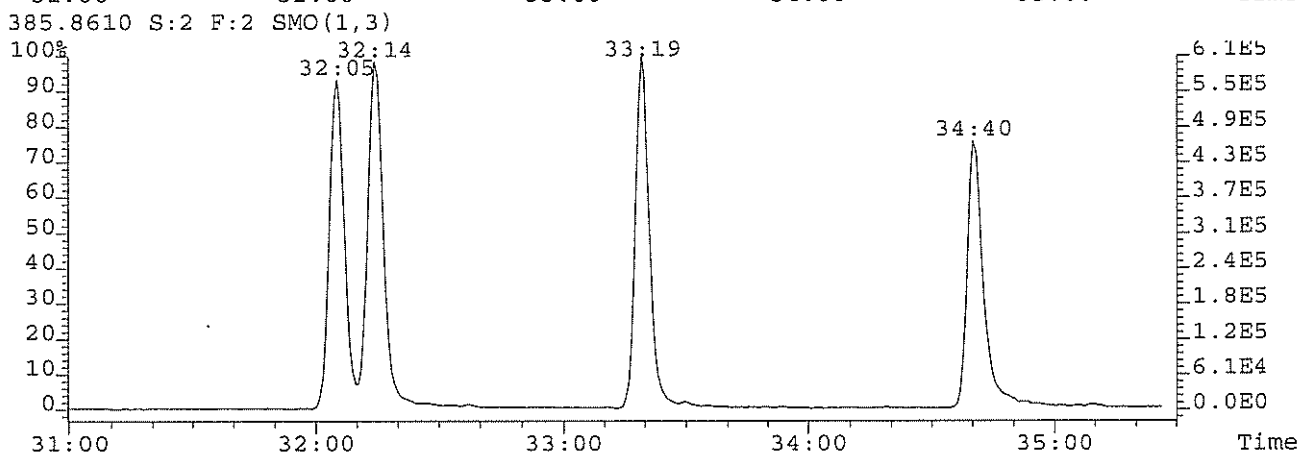
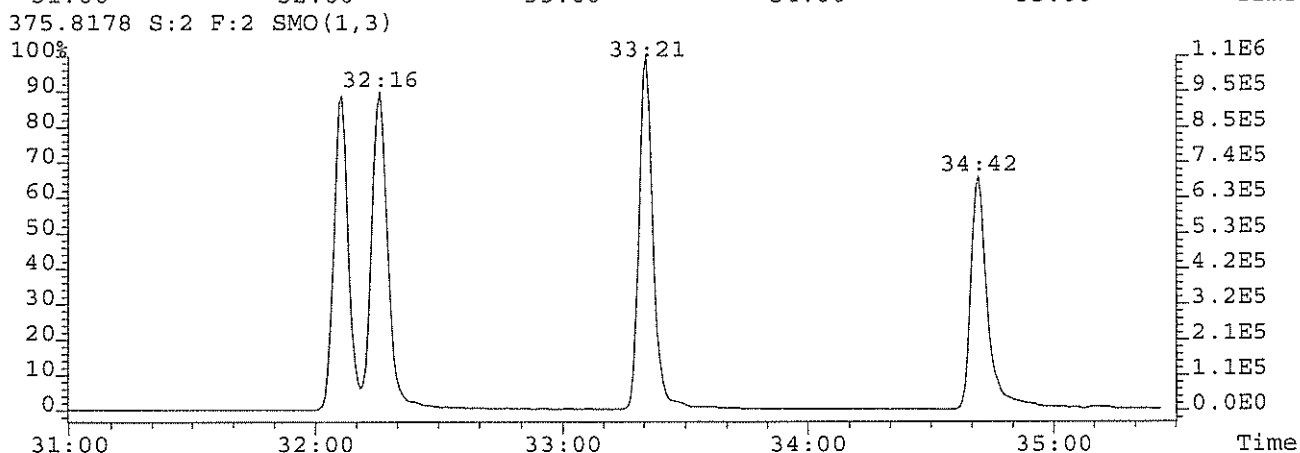
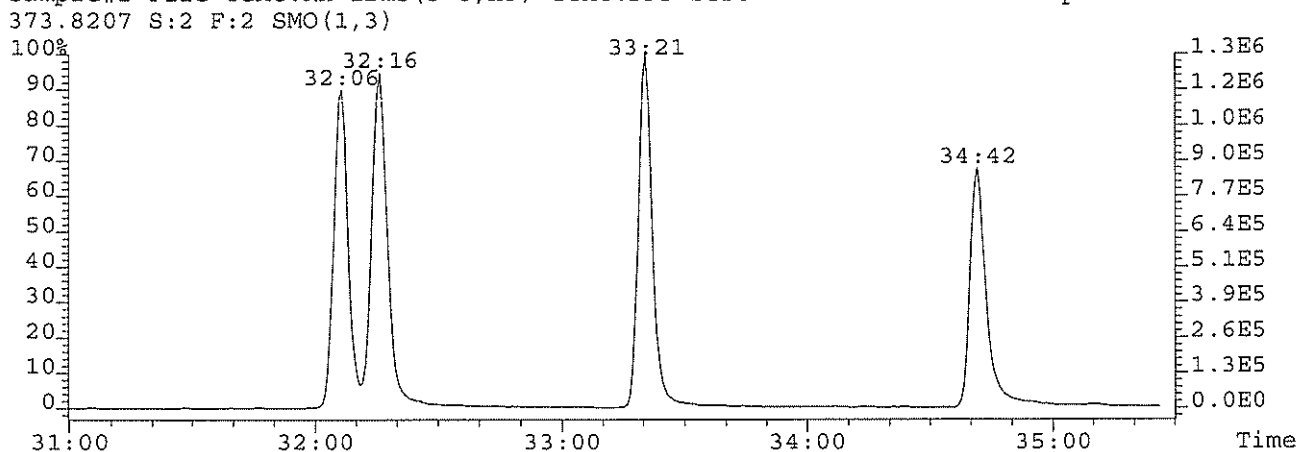


353.8970 S:2 F:2 SMO(1,3)



PeCDFsクロマトグラム (7)  
(23478-PeCDF)

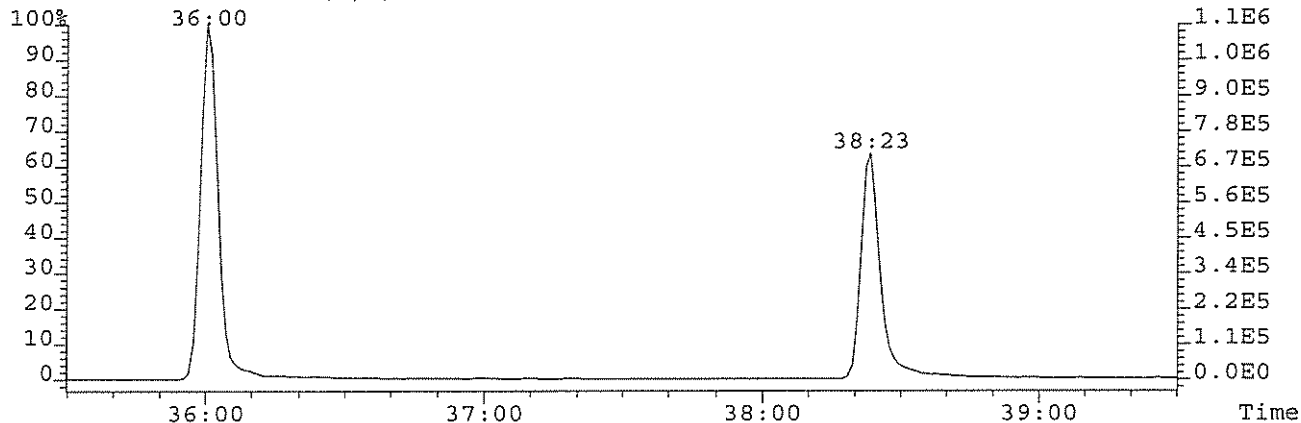
File:130713 #1-649 Acq:13-JUL-2013 13:06:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22



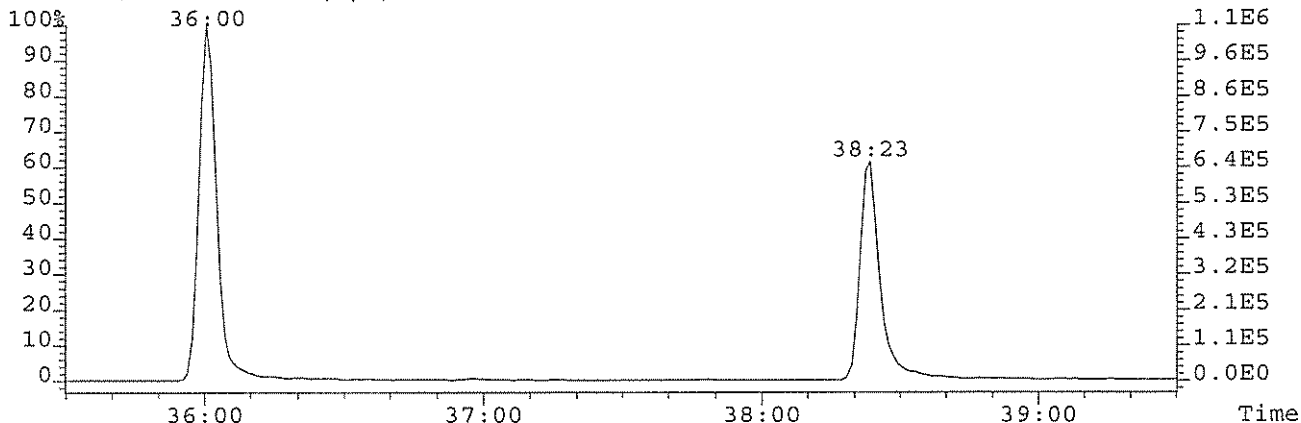
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130713 #1-562 Acq:13-JUL-2013 13:06:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

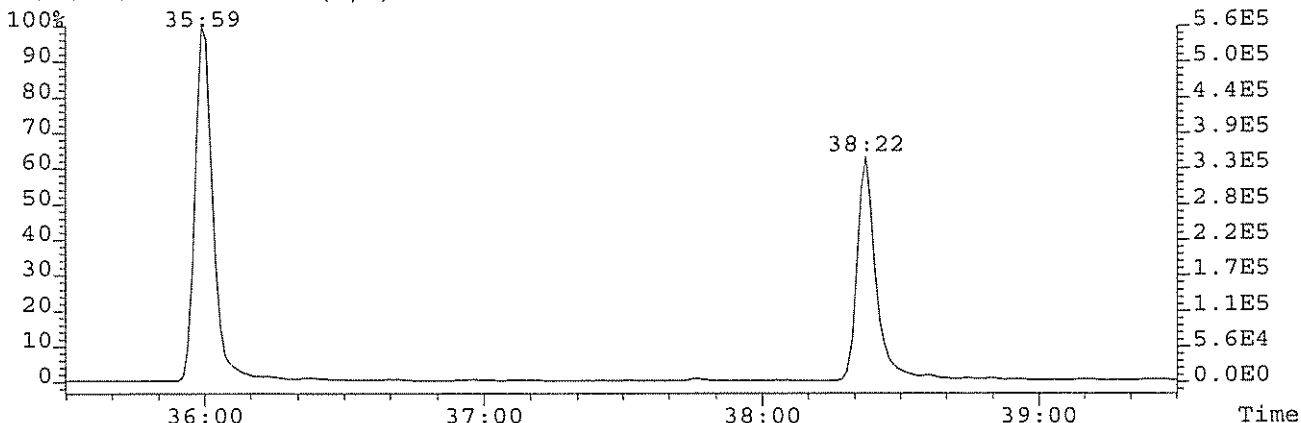
407.7818 S:2 F:3 SMO(1,3)



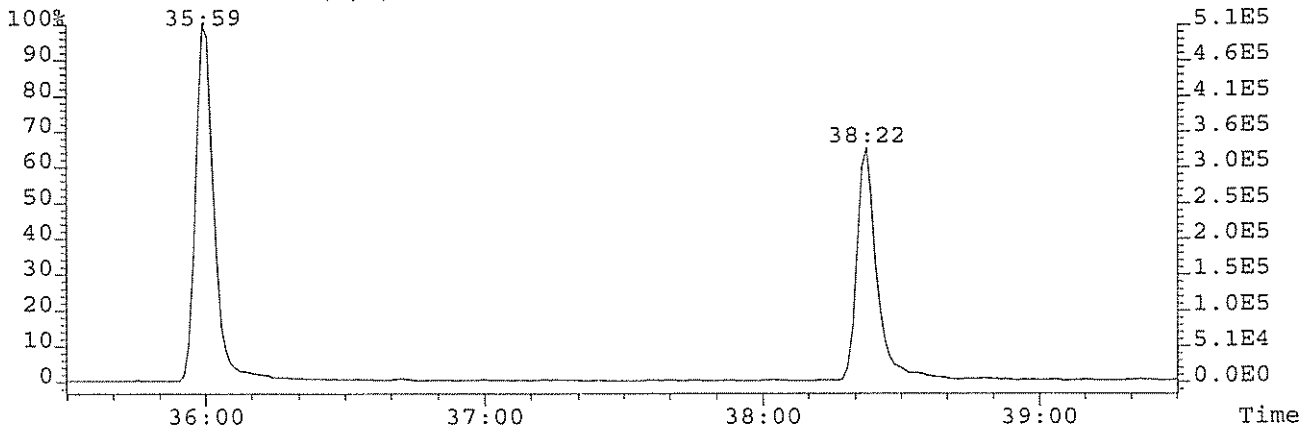
409.7788 S:2 F:3 SMO(1,3)



419.8220 S:2 F:3 SMO(1,3)



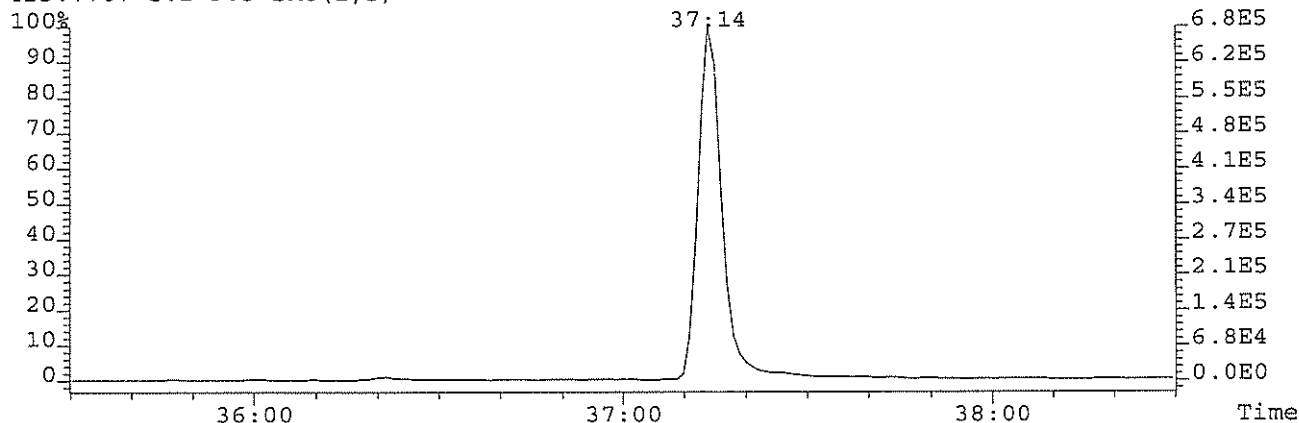
421.8191 S:2 F:3 SMO(1,3)



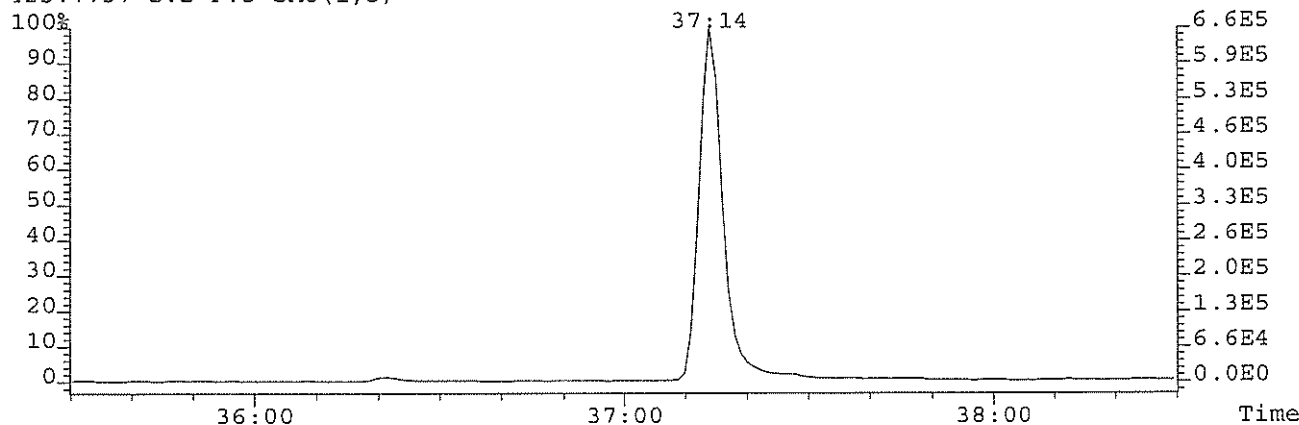
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130713 #1-562 Acq:13-JUL-2013 13:06:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

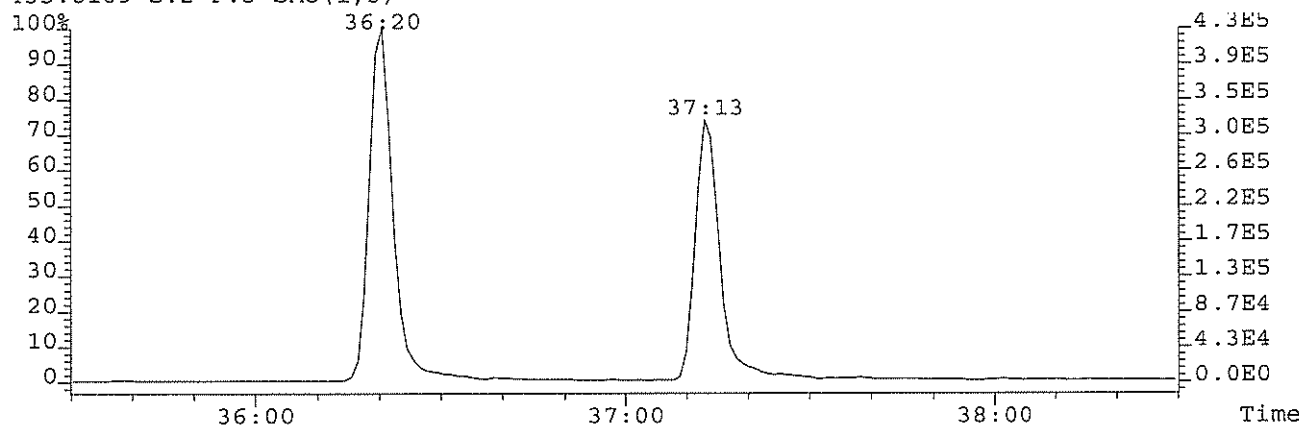
423.7767 S:2 F:3 SMO(1,3)



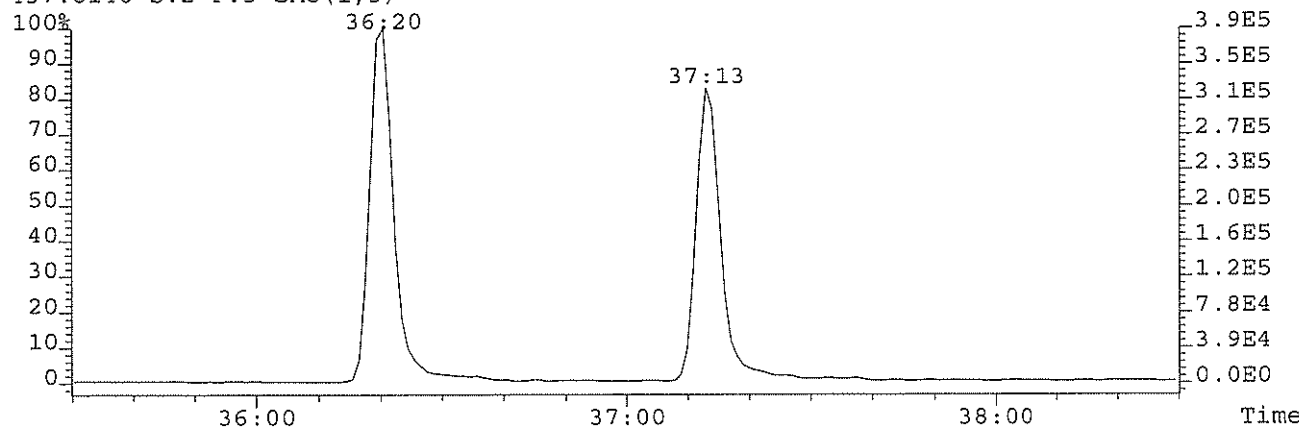
425.7737 S:2 F:3 SMO(1,3)



435.8169 S:2 F:3 SMO(1,3)



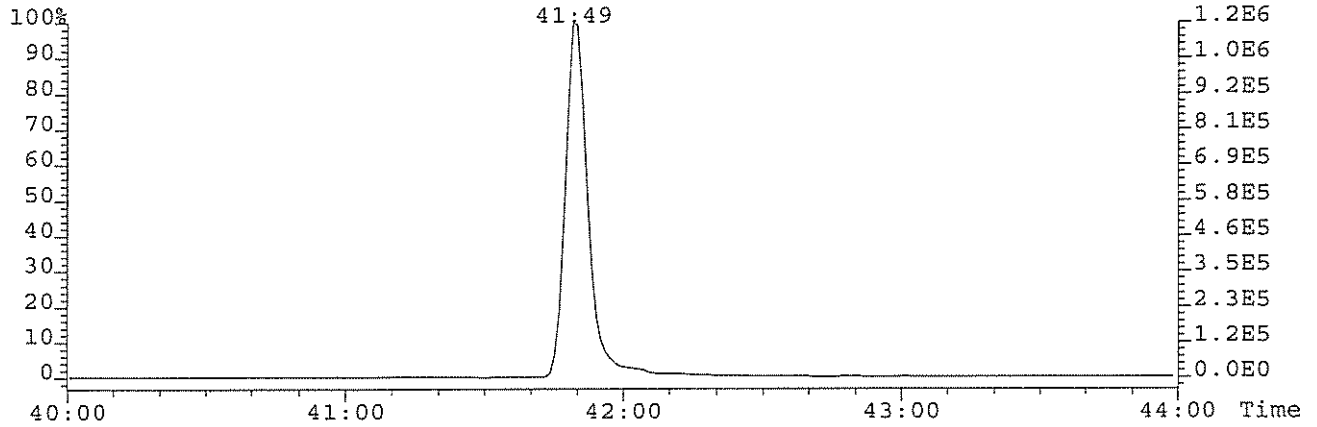
437.8140 S:2 F:3 SMO(1,3)



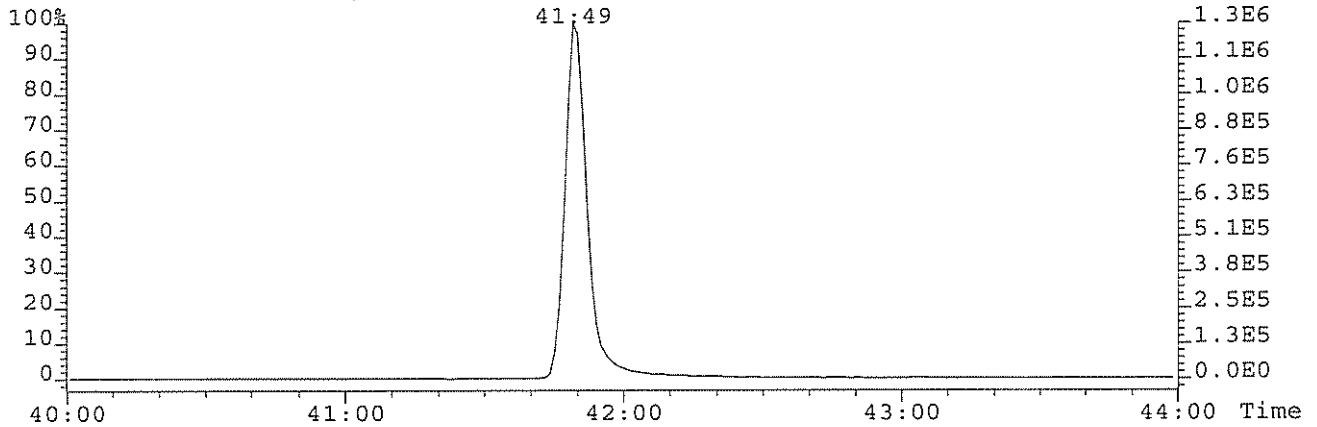
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130713 #1-562 Acq:13-JUL-2013 13:06:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

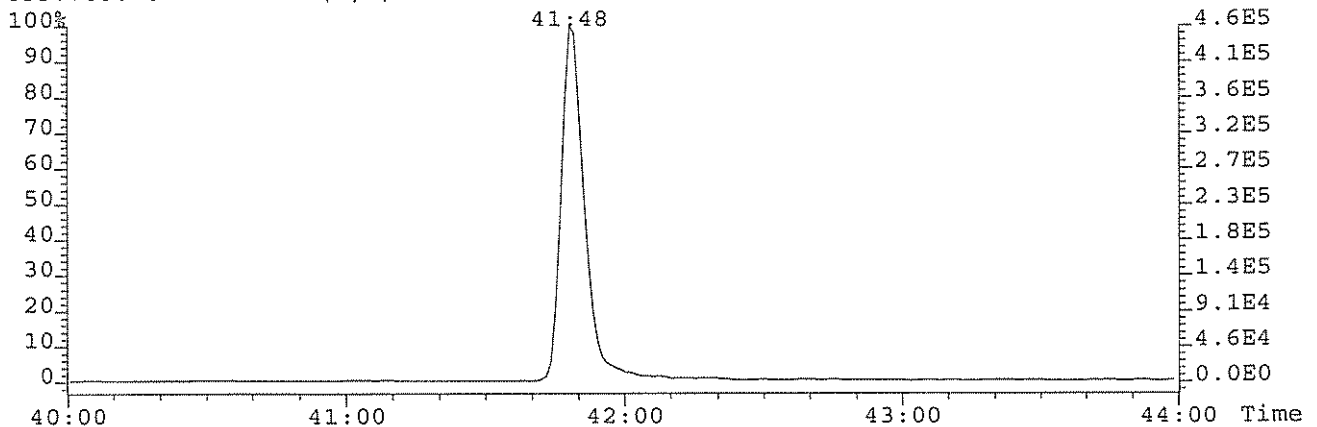
441.7428 S:2 F:3 SMO(1,3)



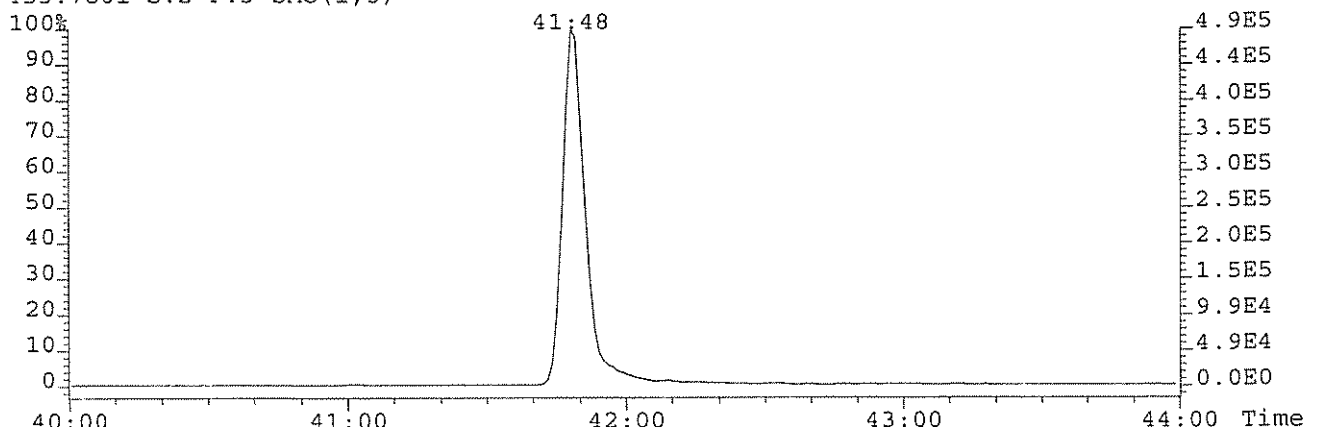
443.7398 S:2 F:3 SMO(1,3)



453.7830 S:2 F:3 SMO(1,3)



455.7801 S:2 F:3 SMO(1,3)

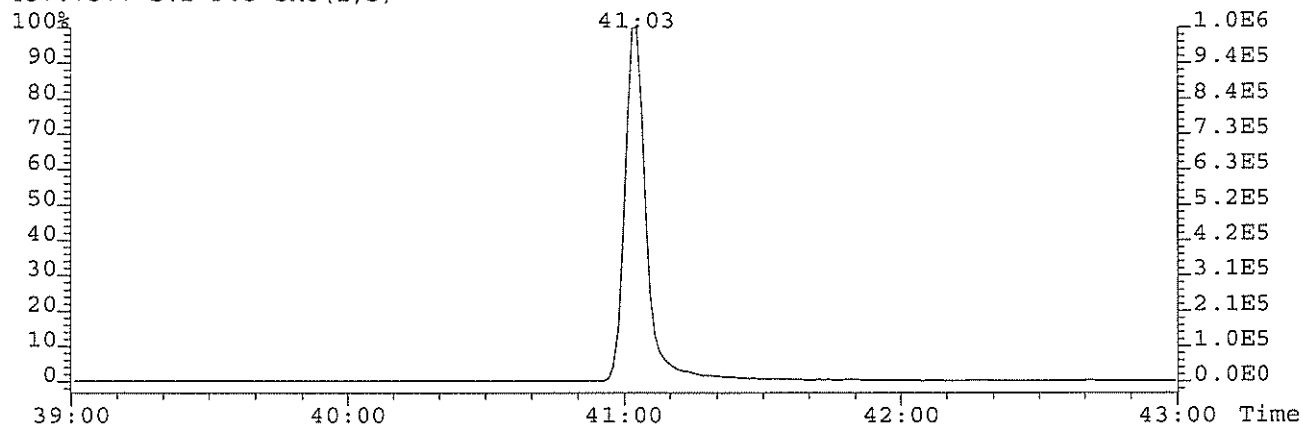


PCDFsクロマトグラム (11)  
(OCDF)

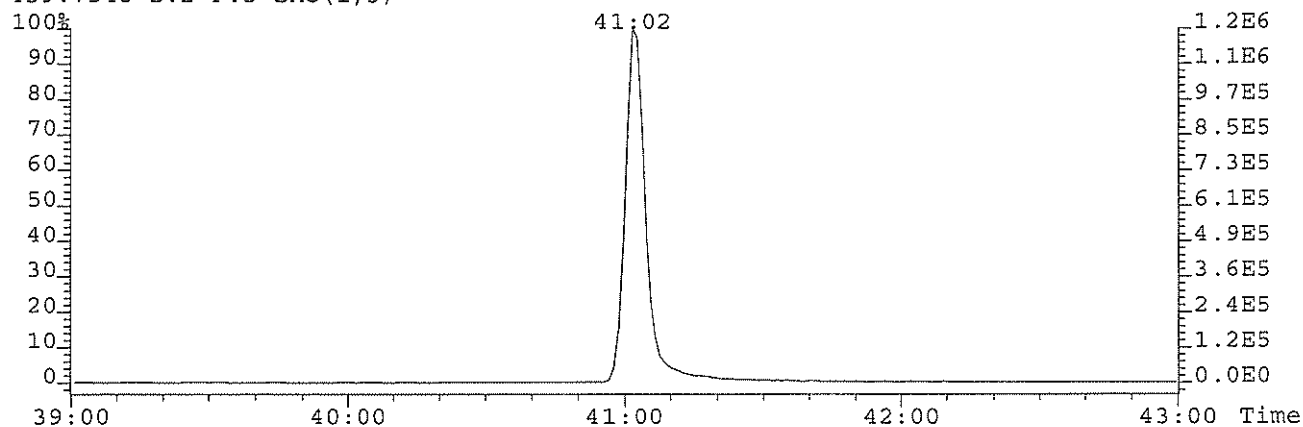


File:130713 #1-562 Acq:13-JUL-2013 13:06:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

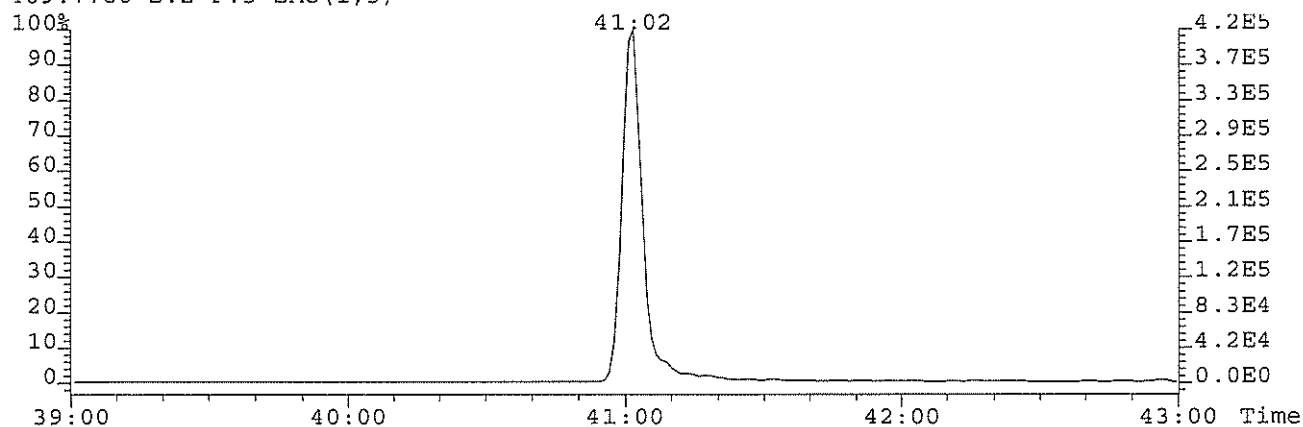
457.7377 S:2 F:3 SMO(1,3)



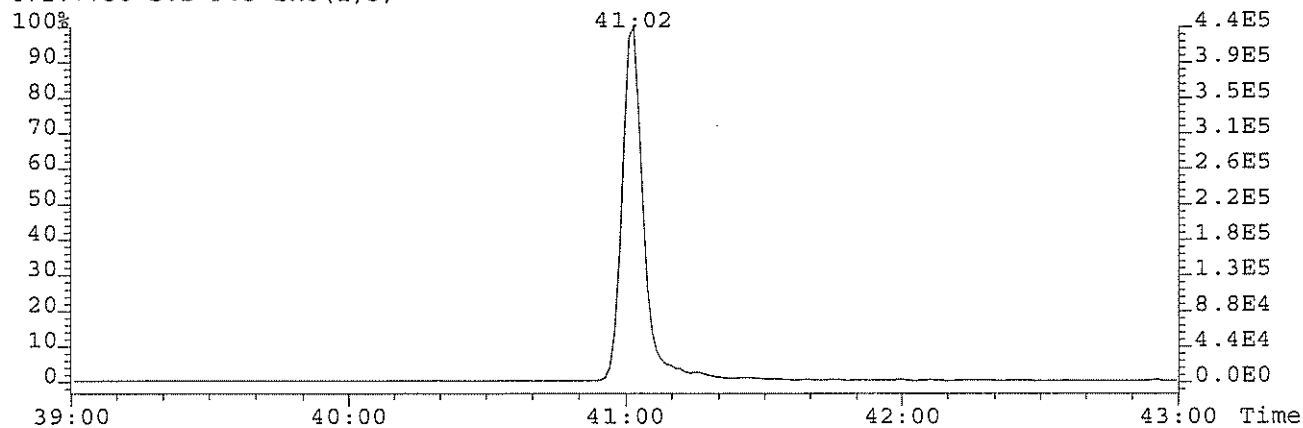
459.7348 S:2 F:3 SMO(1,3)



469.7780 S:2 F:3 SMO(1,3)

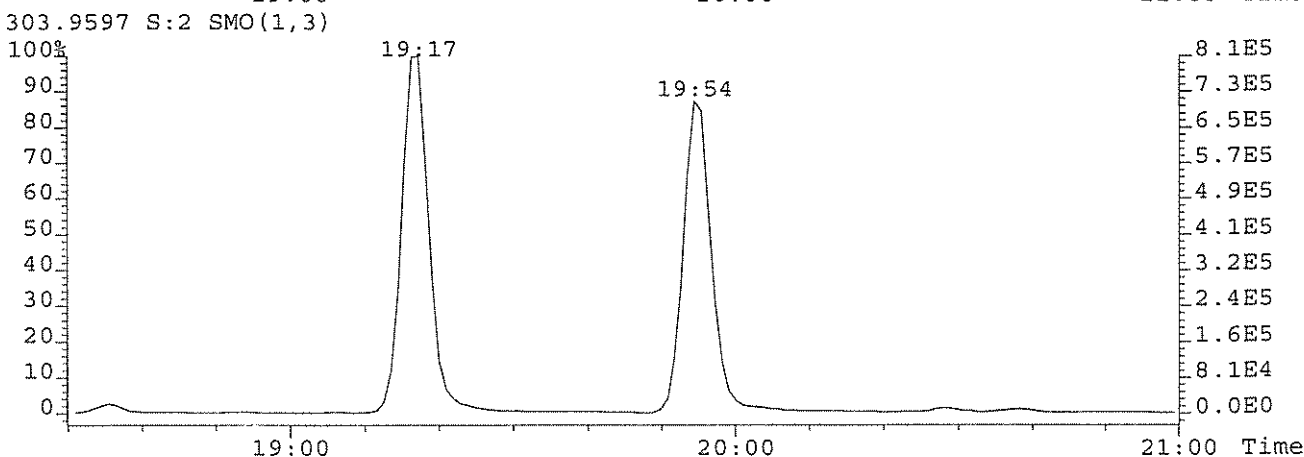
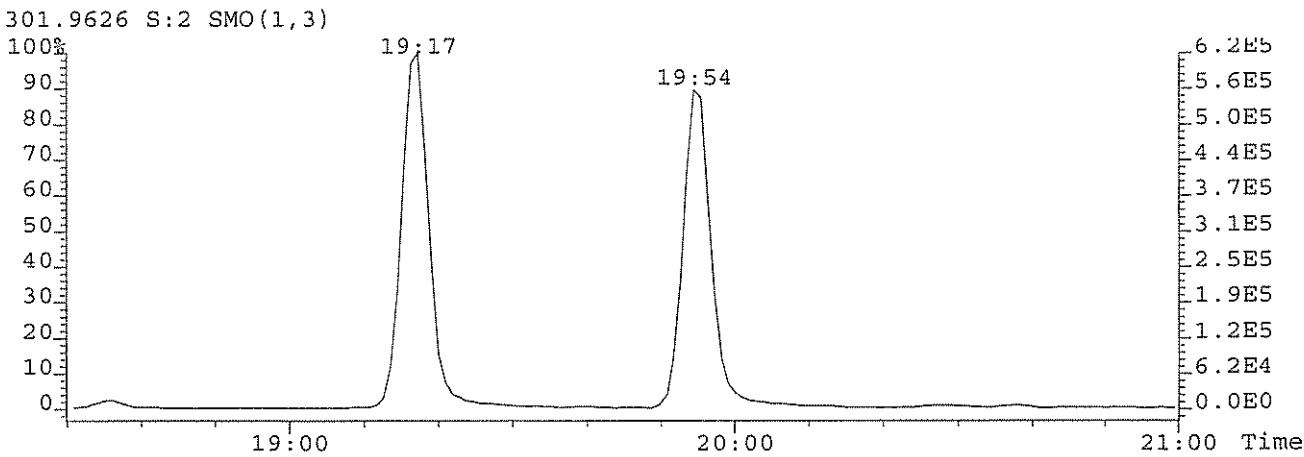
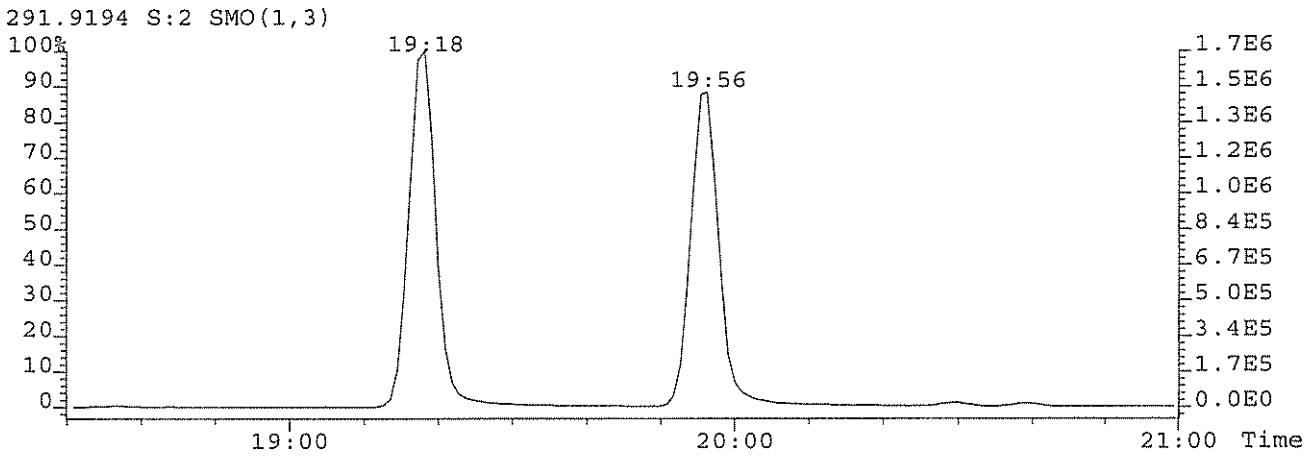
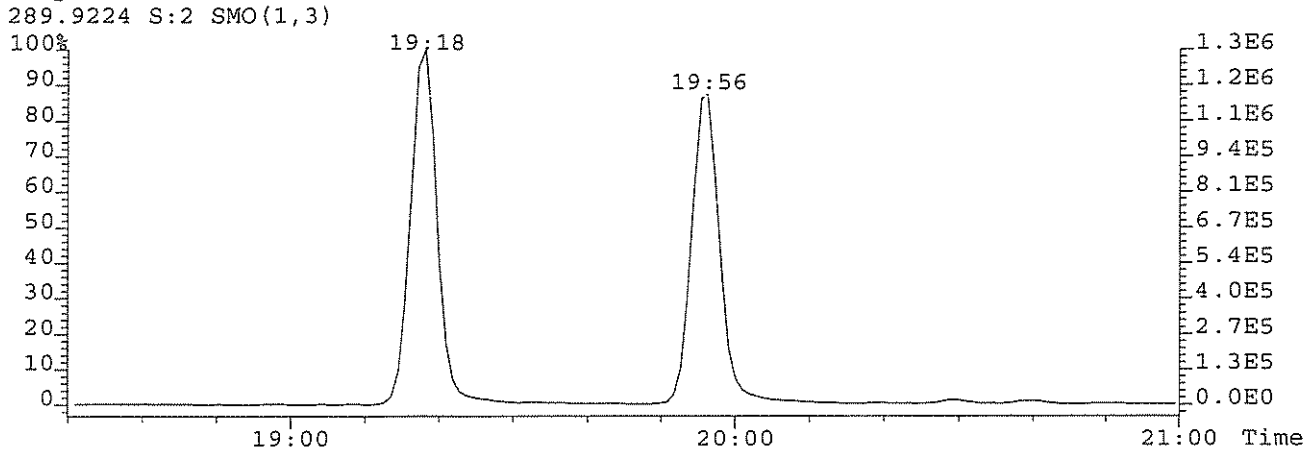


471.7750 S:2 F:3 SMO(1,3)



PCDDsクロマトグラム (12)  
(OCDD)

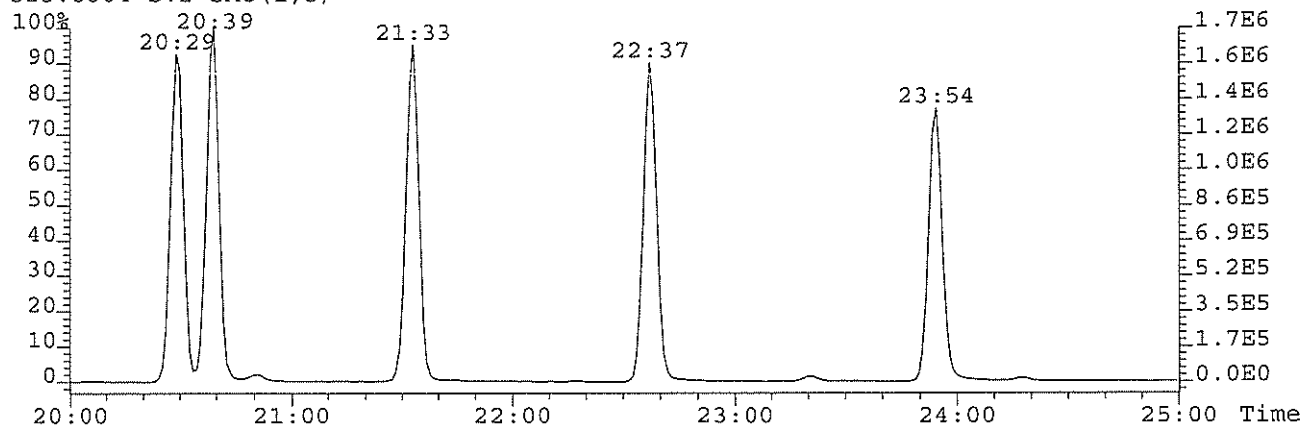
File:130713 #1-1430 Acq:13-JUL-2013 13:06:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22



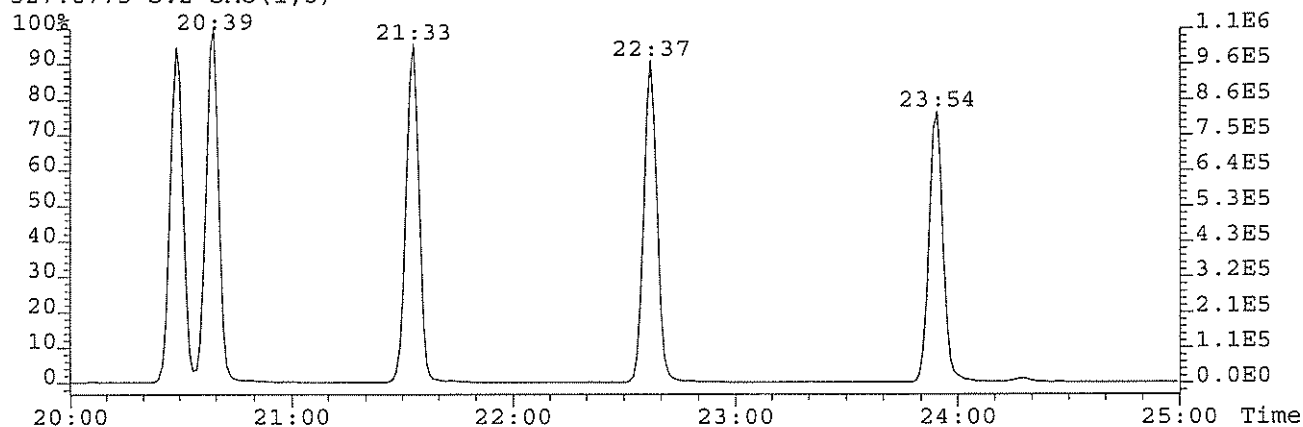
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130713 #1-1430 Acq:13-JUL-2013 13:06:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

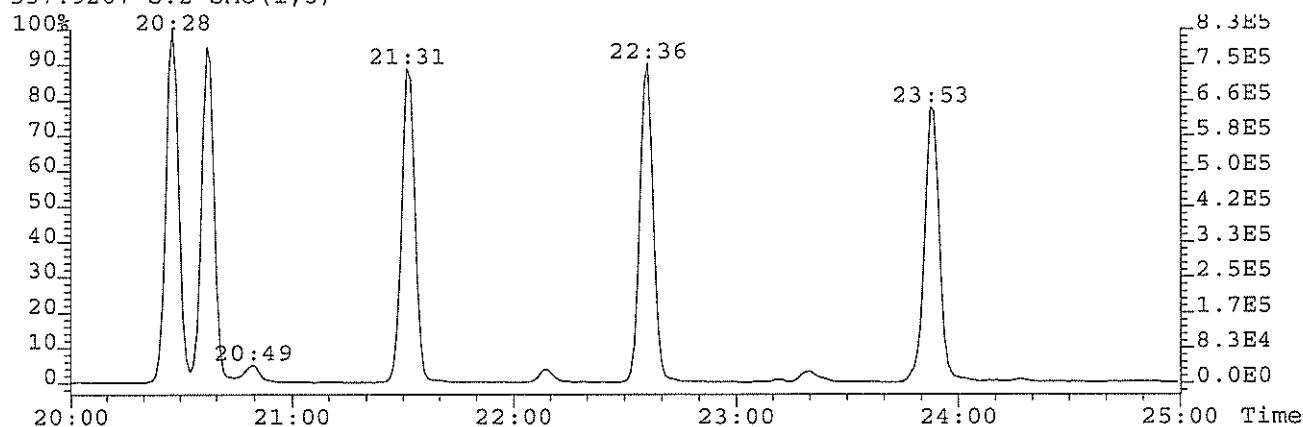
325.8804 S:2 SMO(1,3)



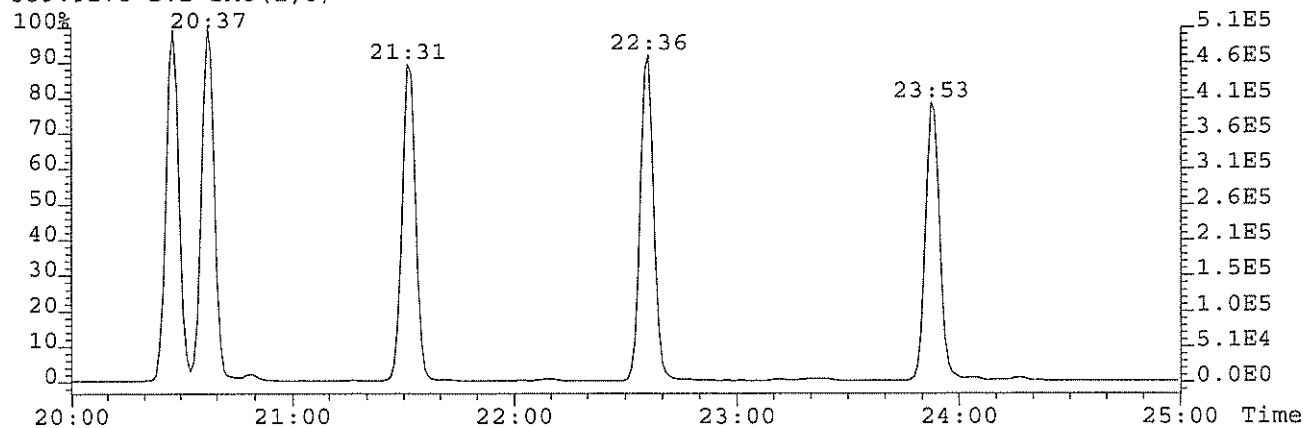
327.8775 S:2 SMO(1,3)



337.9207 S:2 SMO(1,3)

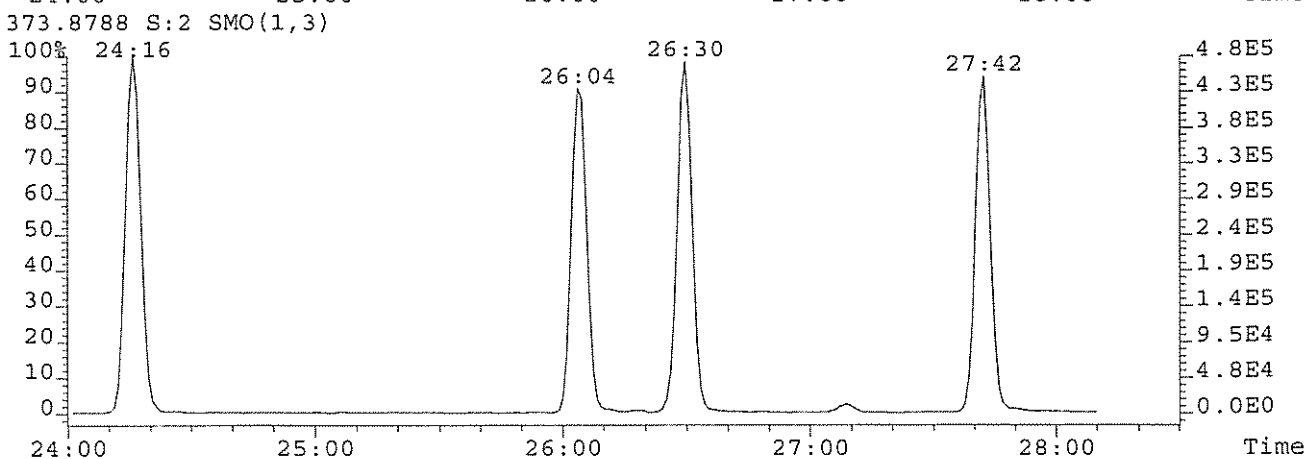
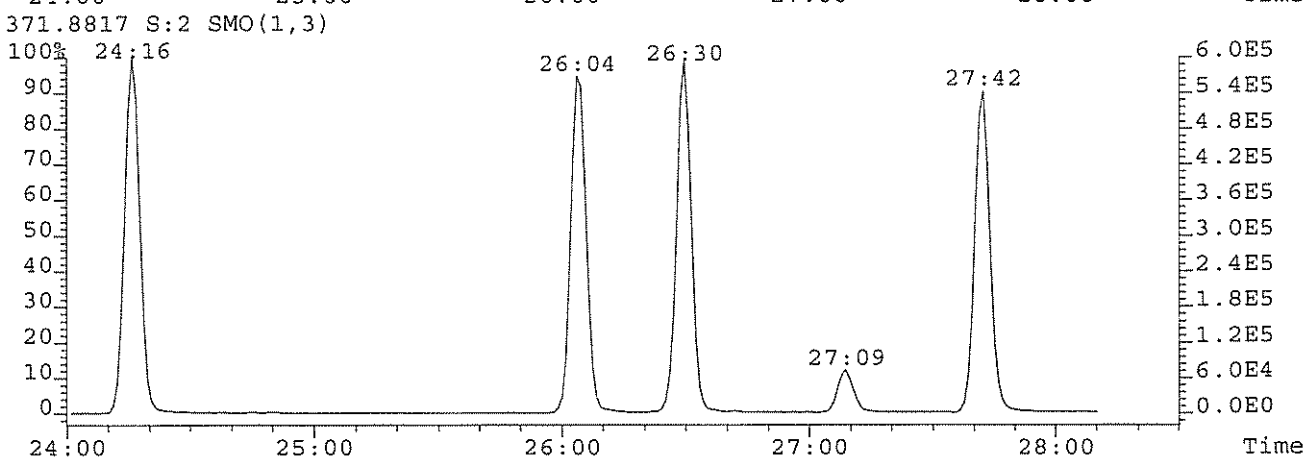
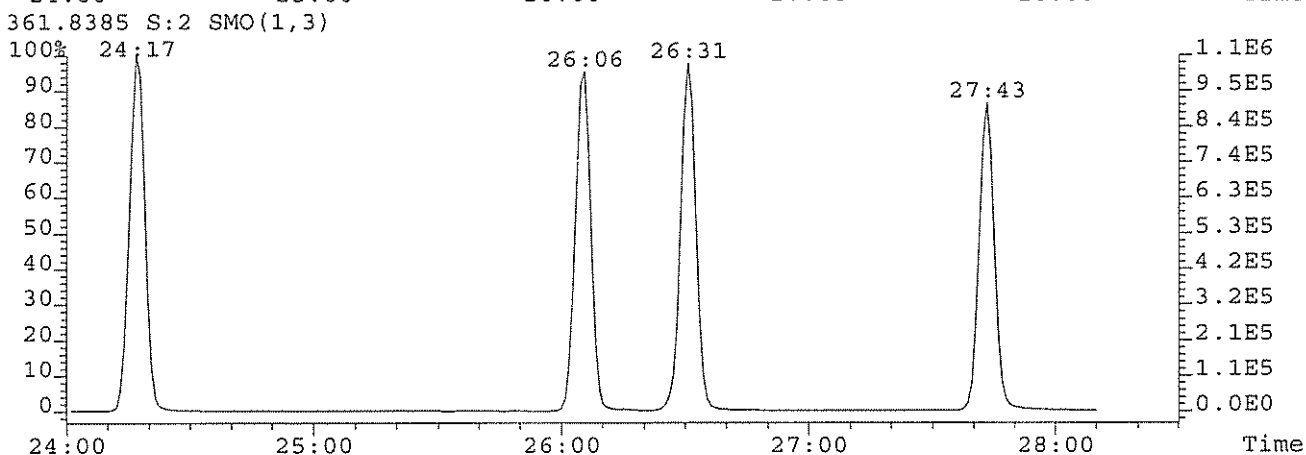
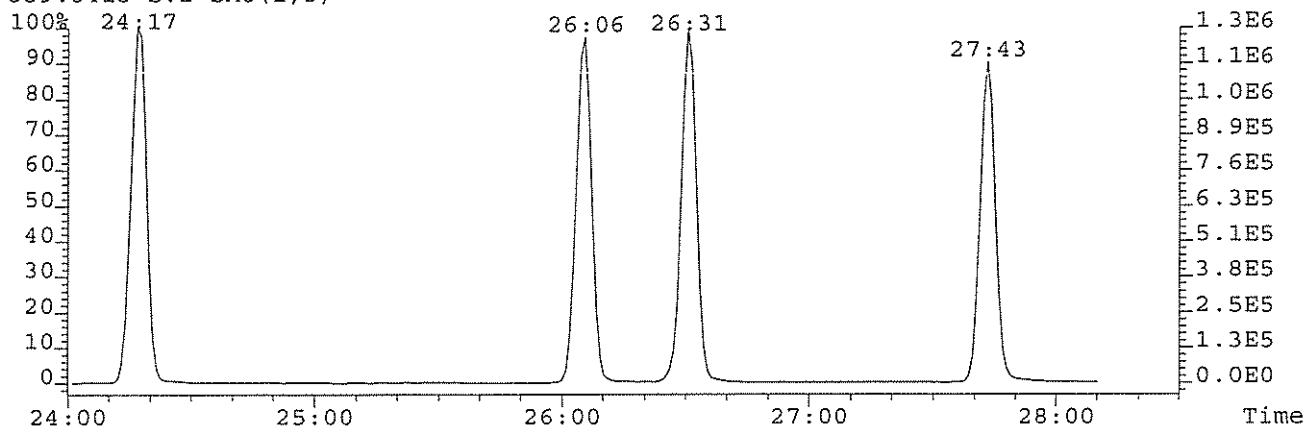


339.9178 S:2 SMO(1,3)



DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

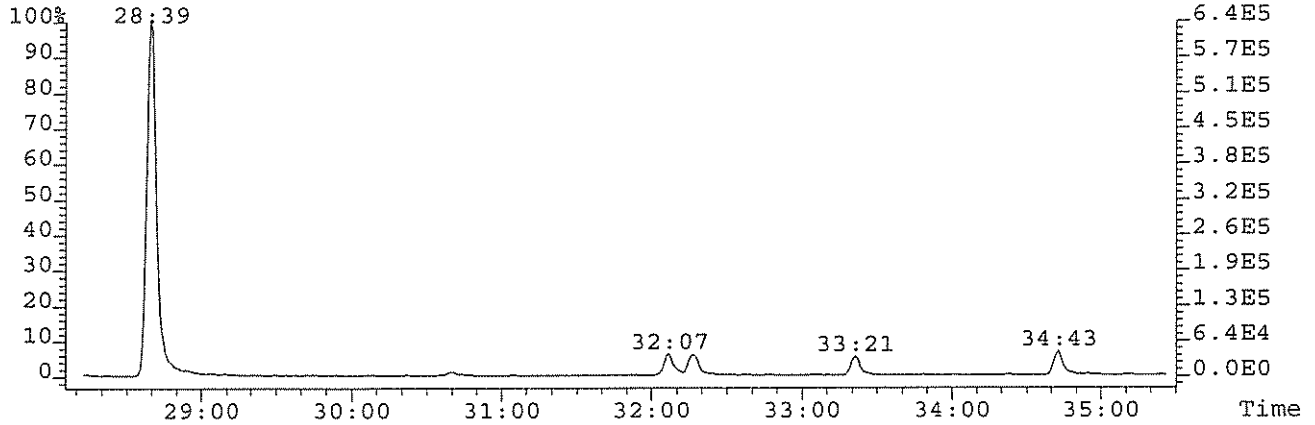
File:130713 #1-1430 Acq:13-JUL-2013 13:06:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22  
359.8415 S:2 SMO(1,3)



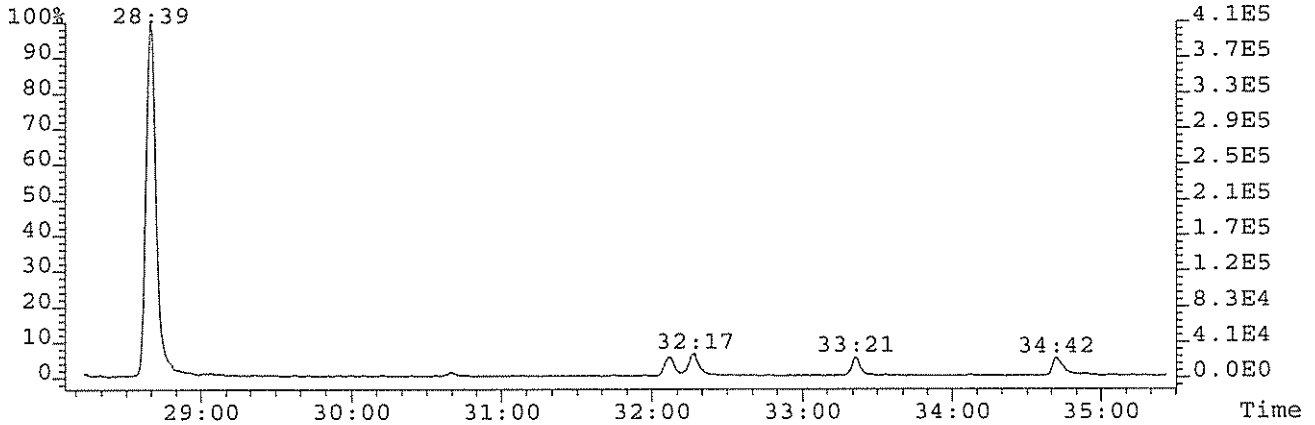
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

標準物質	
測定日	平成25年7月16日
測定物質	2,3,4,7,8-PeCDF, 1,2,3,7,8,9-HxCDF HpCDDs/DFs, OCDD/DFの同族体及び 2,3,7,8-位塩素置換異性体, Non-ortho PCB

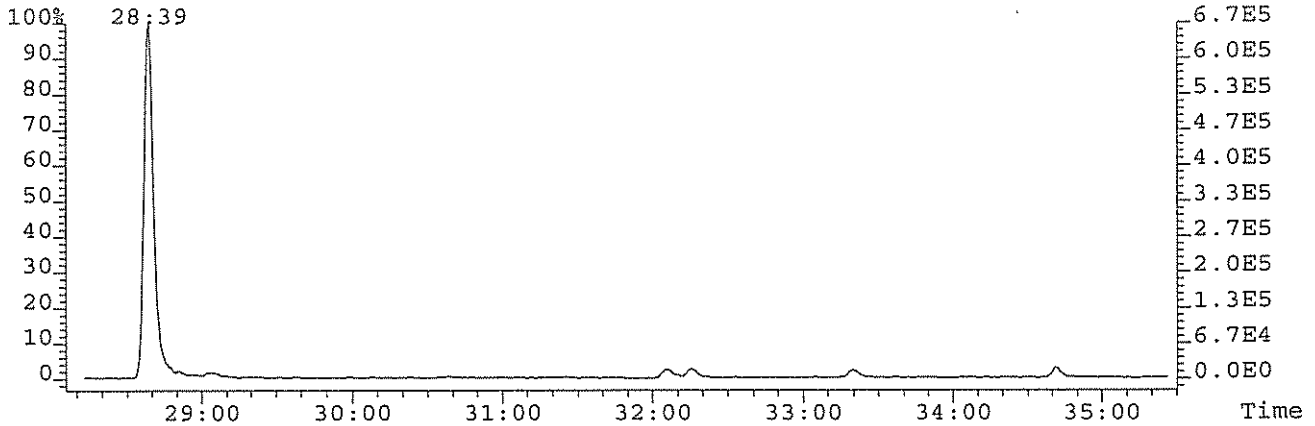
File:130716 #1-649 Acq:16-JUL-2013 11:00:38 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22  
339.8597 S:2 F:2 SMO(1,3)



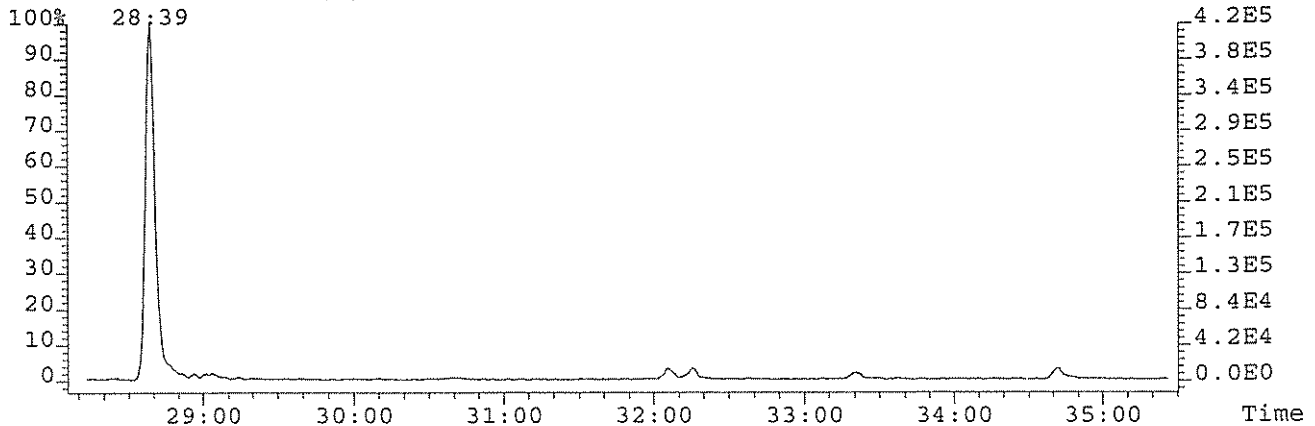
341.8568 S:2 F:2 SMO(1,3)



351.9000 S:2 F:2 SMO(1,3)

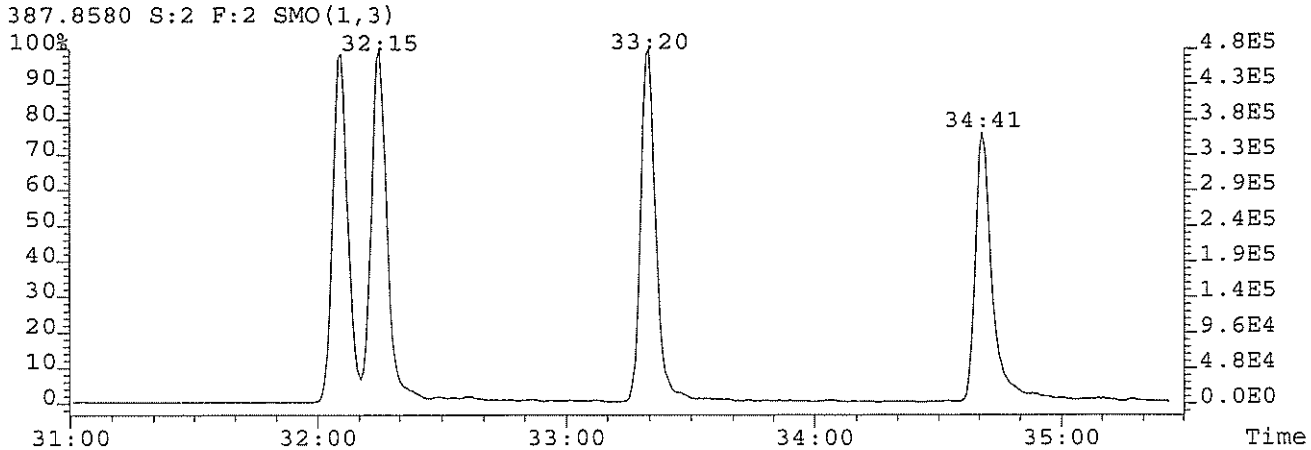
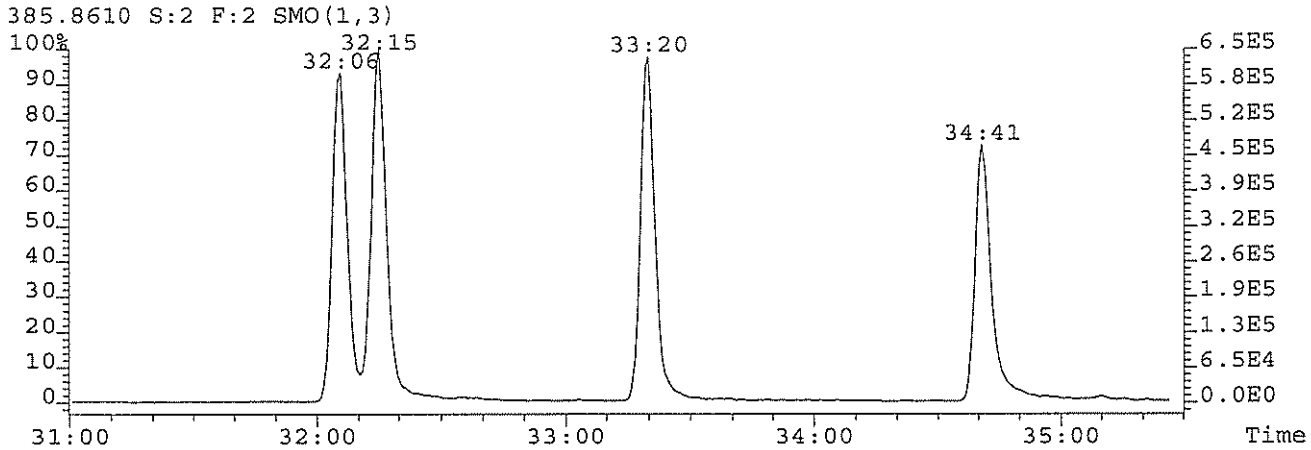
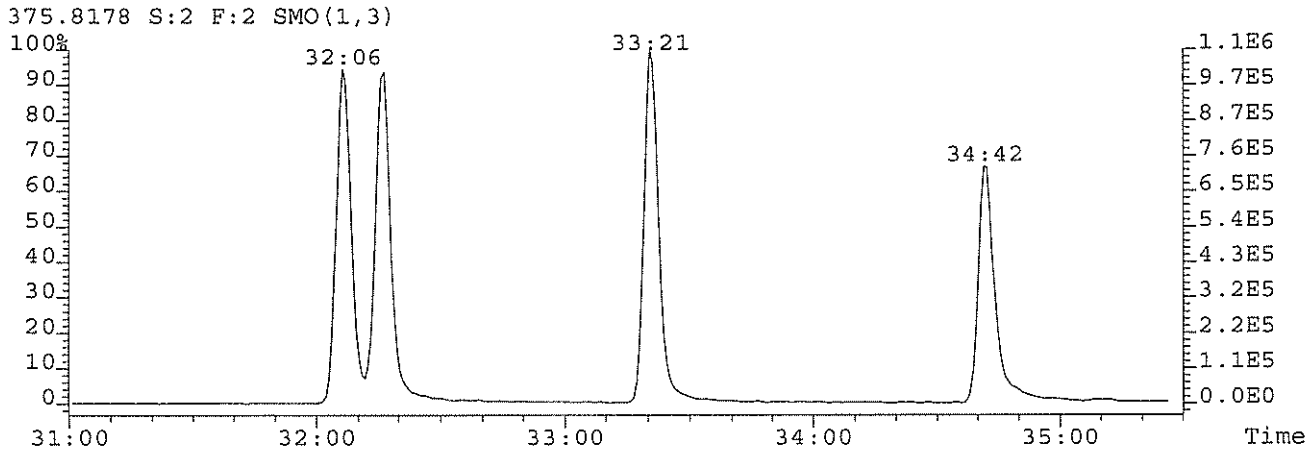
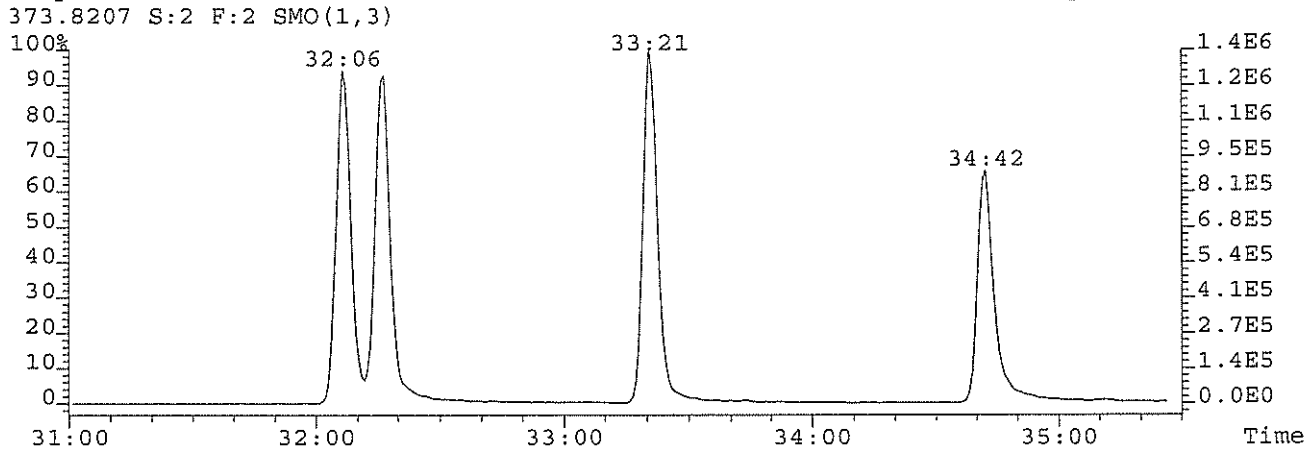


353.8970 S:2 F:2 SMO(1,3)



PeCDFsクロマトグラム (7)  
(23478-PeCDF)

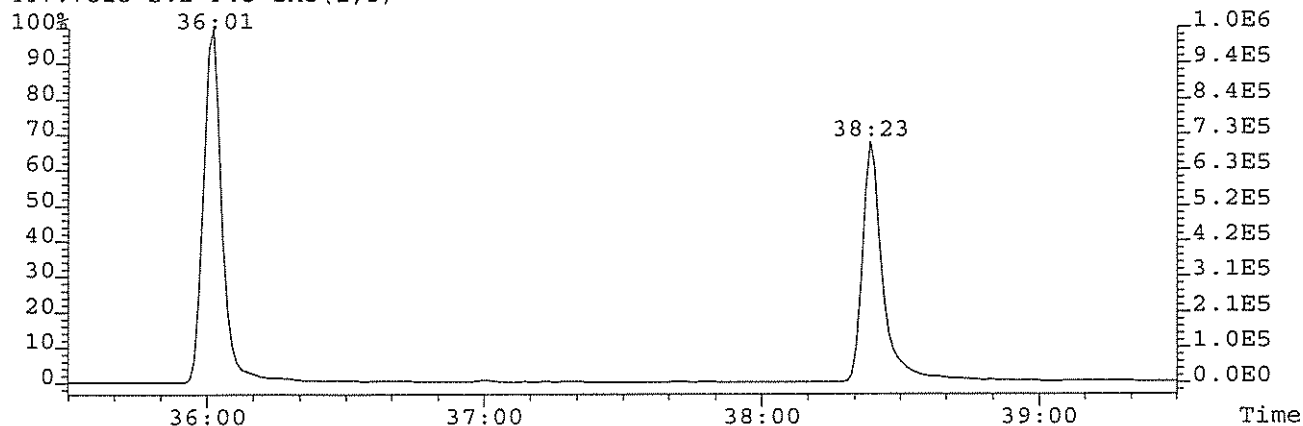
File:130716 #1-649 Acq:16-JUL-2013 11:00:38 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22



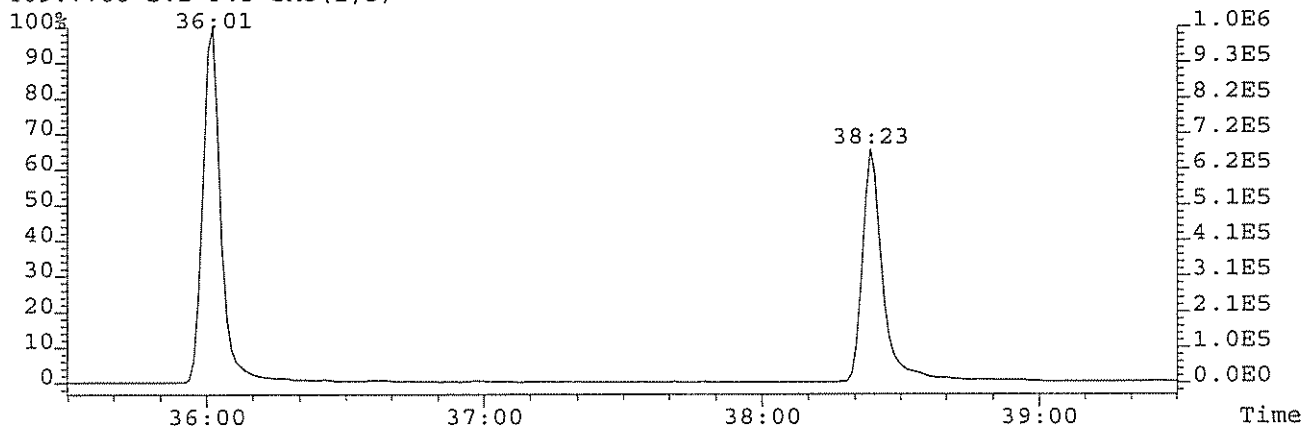
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130716 #1-562 Acq:16-JUL-2013 11:00:38 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

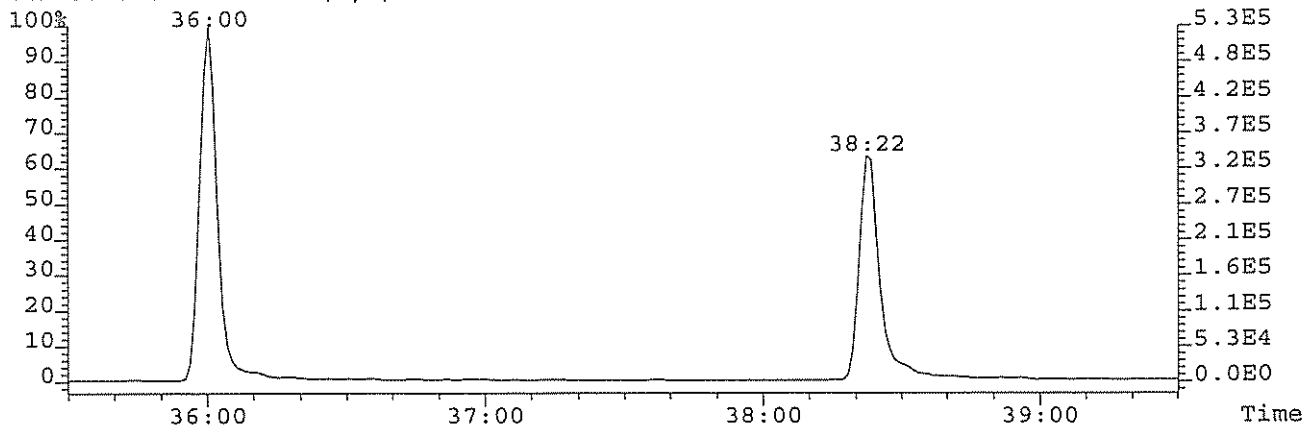
407.7818 S:2 F:3 SMO(1,3)



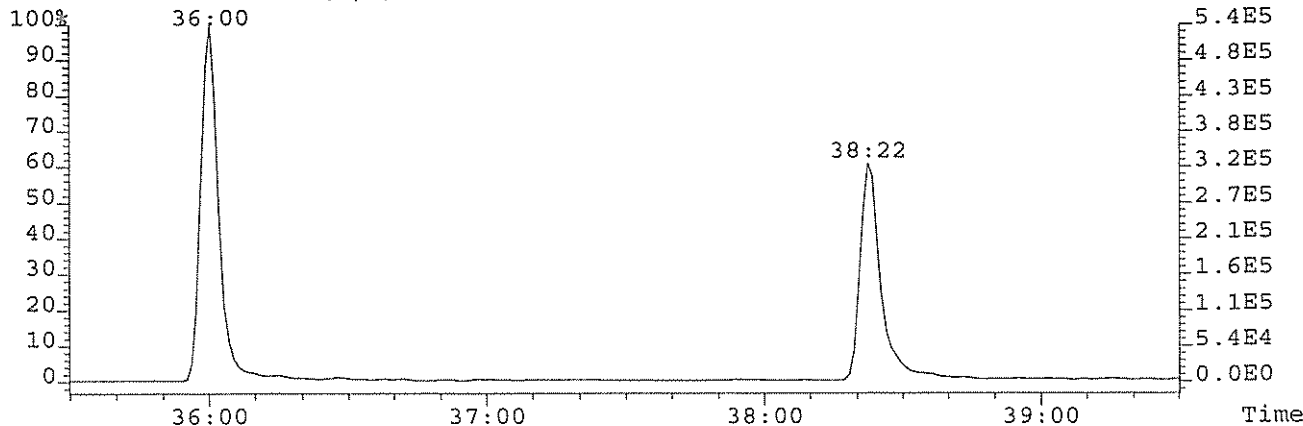
409.7788 S:2 F:3 SMO(1,3)



419.8220 S:2 F:3 SMO(1,3)



421.8191 S:2 F:3 SMO(1,3)

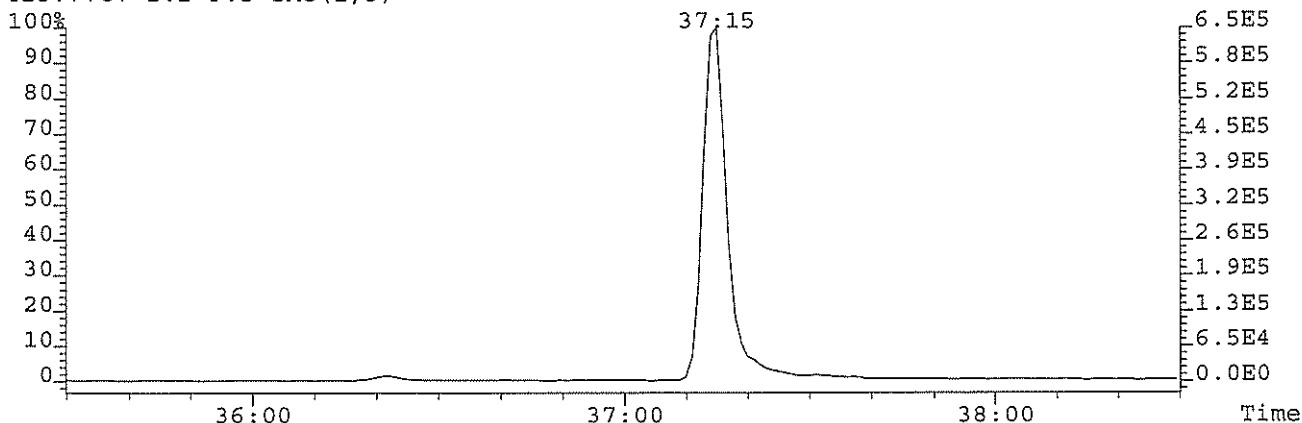


PCDFsクロマトグラム (9)  
(HpCDFs)

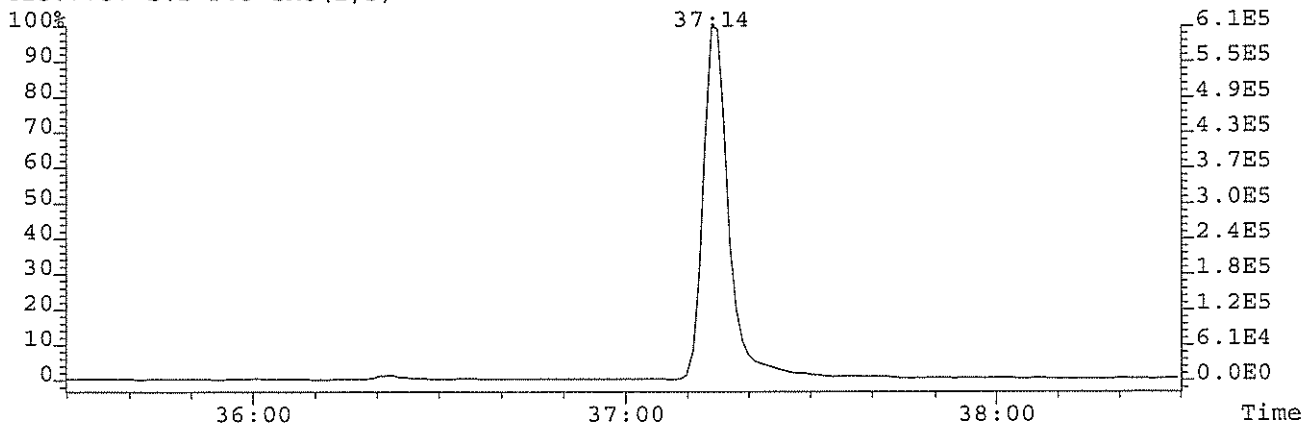


File:130716 #1-562 Acq:16-JUL-2013 11:00:38 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

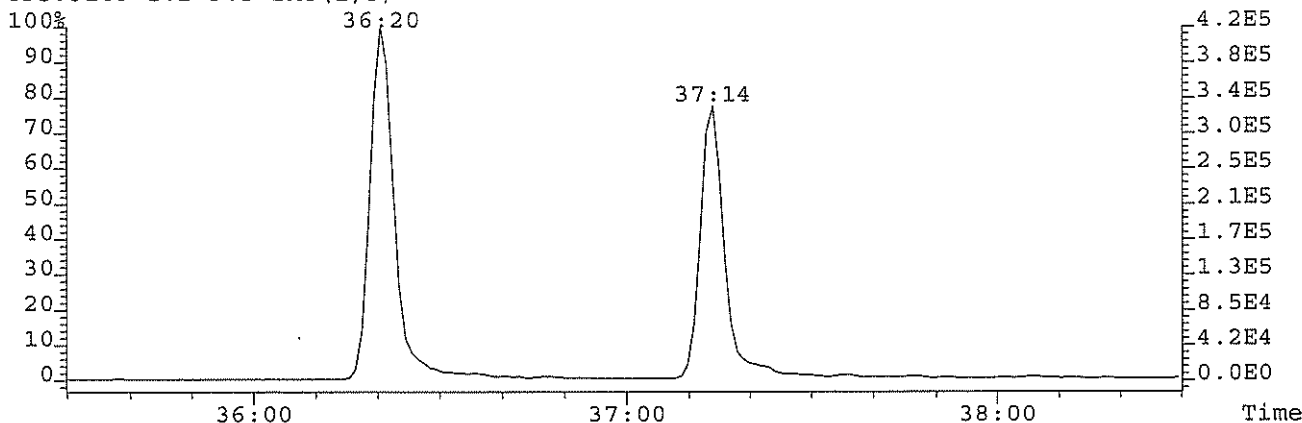
423.7767 S:2 F:3 SMO(1,3)



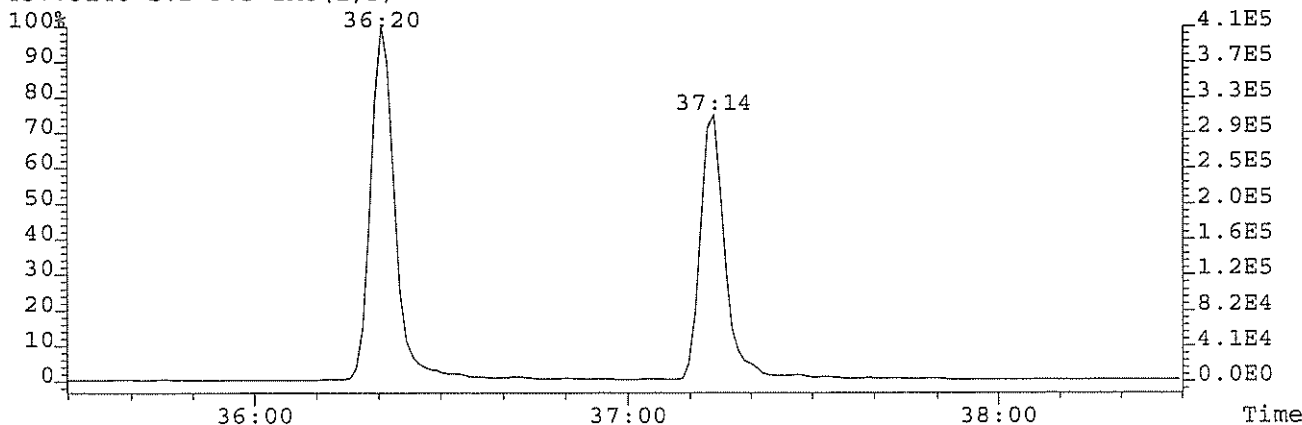
425.7737 S:2 F:3 SMO(1,3)



435.8169 S:2 F:3 SMO(1,3)

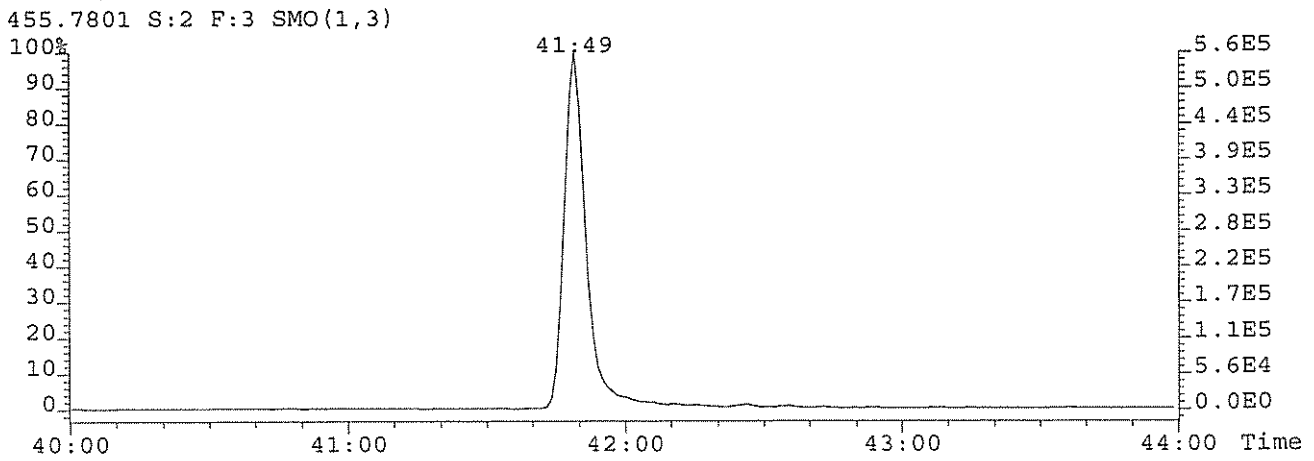
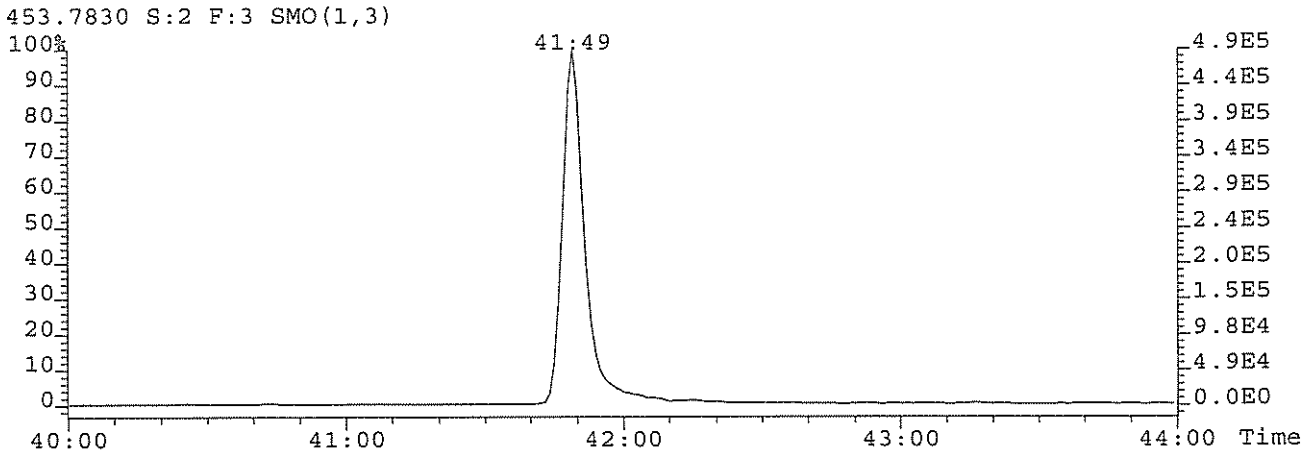
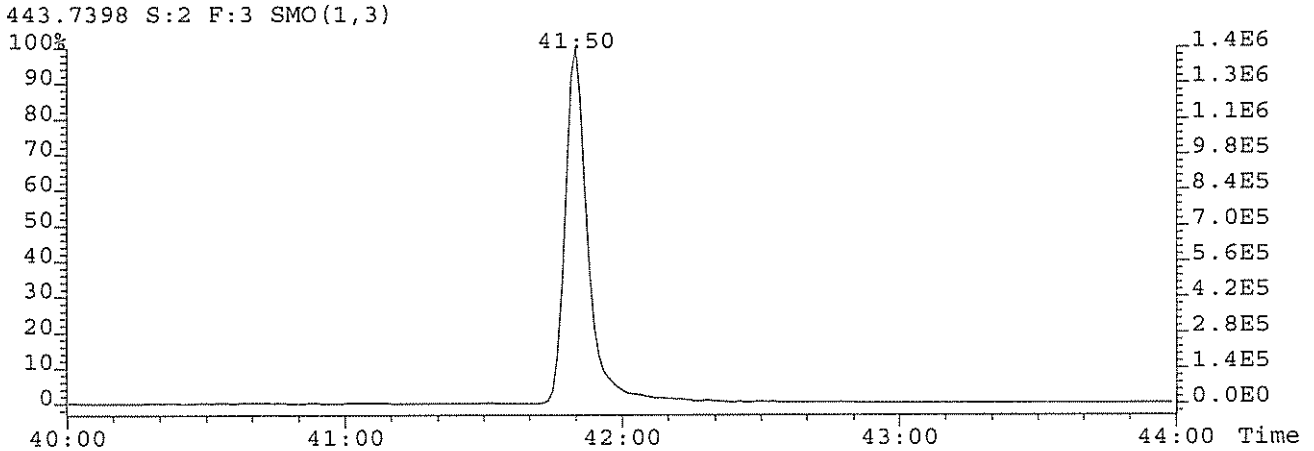
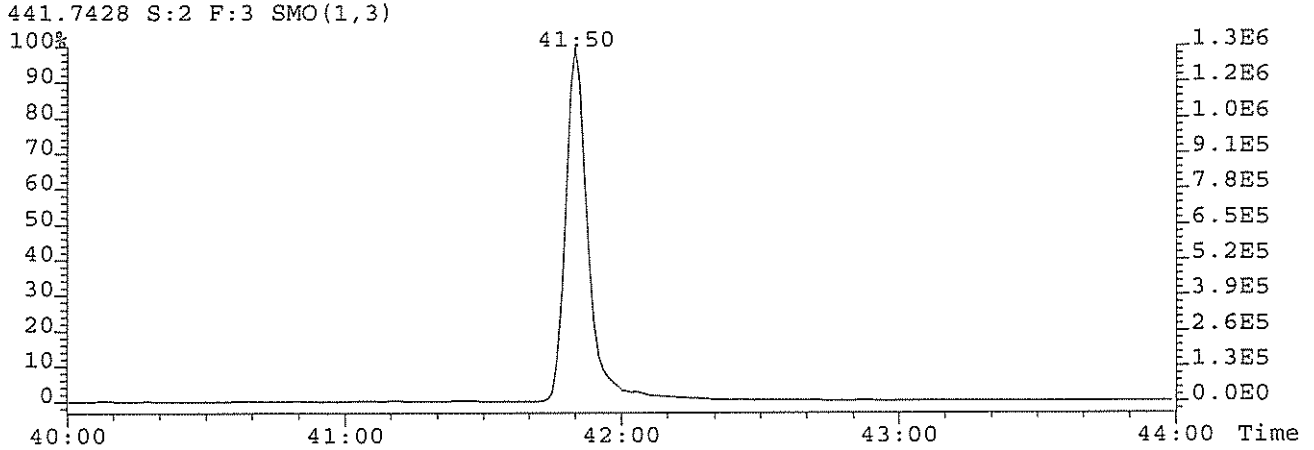


437.8140 S:2 F:3 SMO(1,3)



PCDDsクロマトグラム (10)  
(HpCDDs)

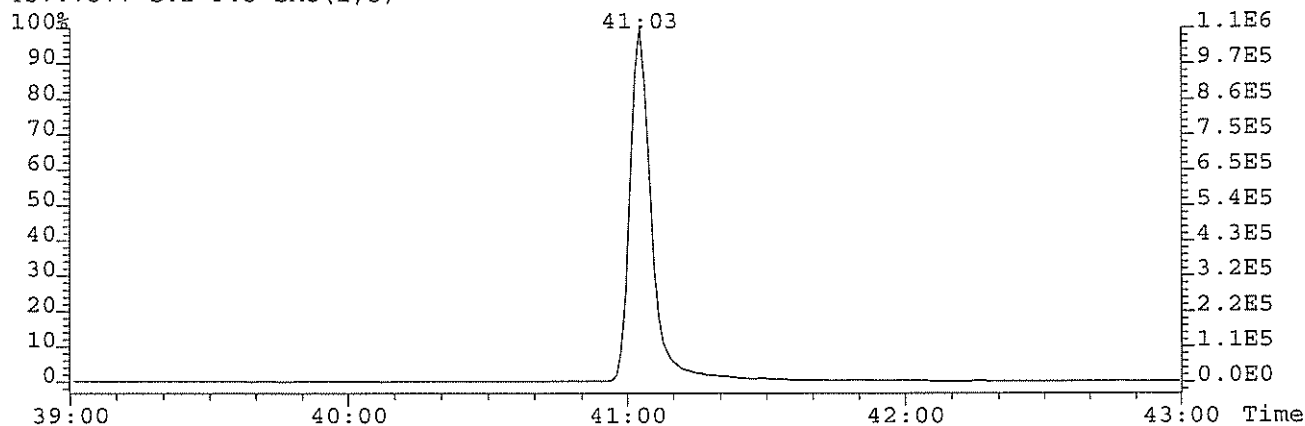
File:130716 #1-562 Acq:16-JUL-2013 11:00:38 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22



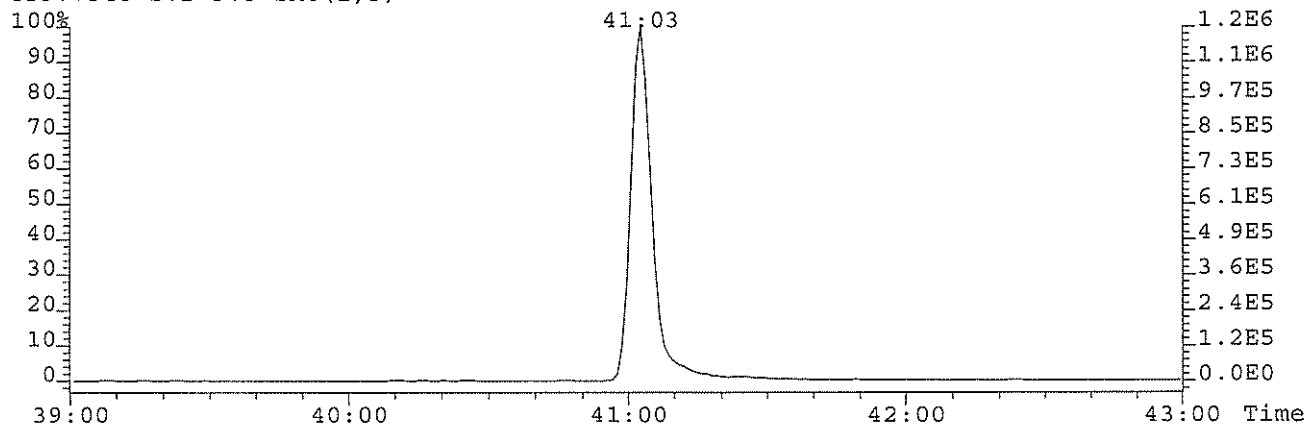
PCDFsクロマトグラム (11)  
(OCDF)

File:130716 #1-562 Acq:16-JUL-2013 11:00:38 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

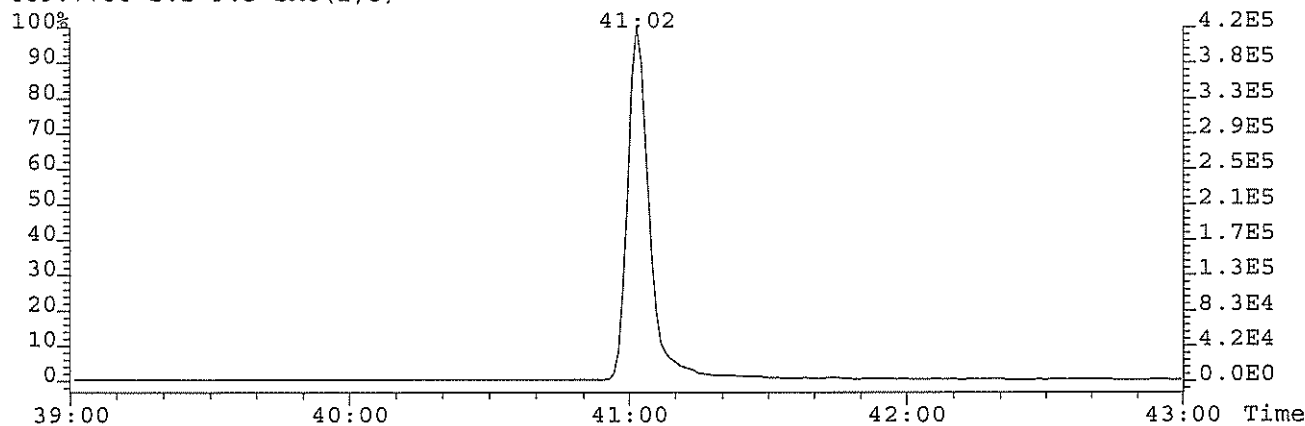
457.7377 S:2 F:3 SMO(1,3)



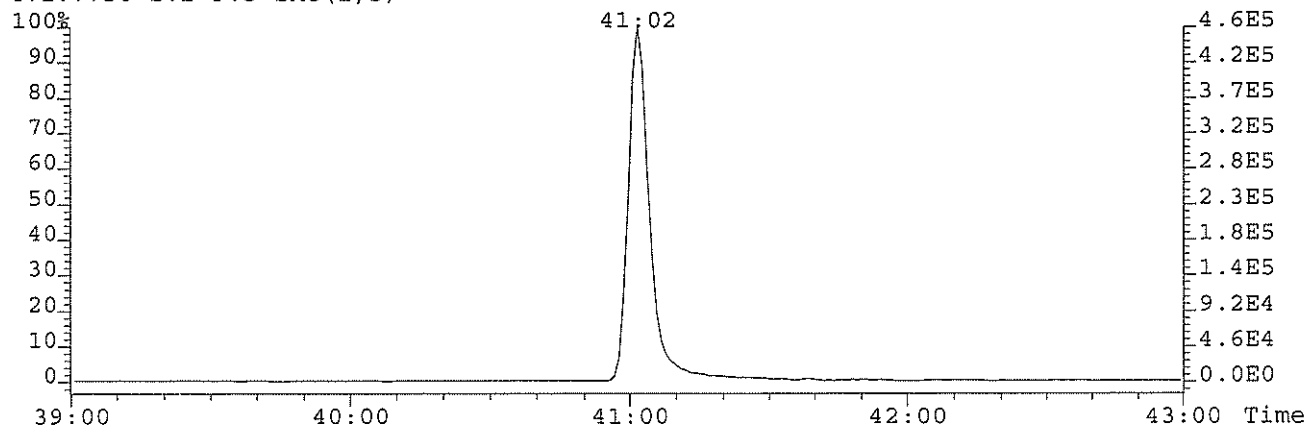
459.7348 S:2 F:3 SMO(1,3)



469.7780 S:2 F:3 SMO(1,3)

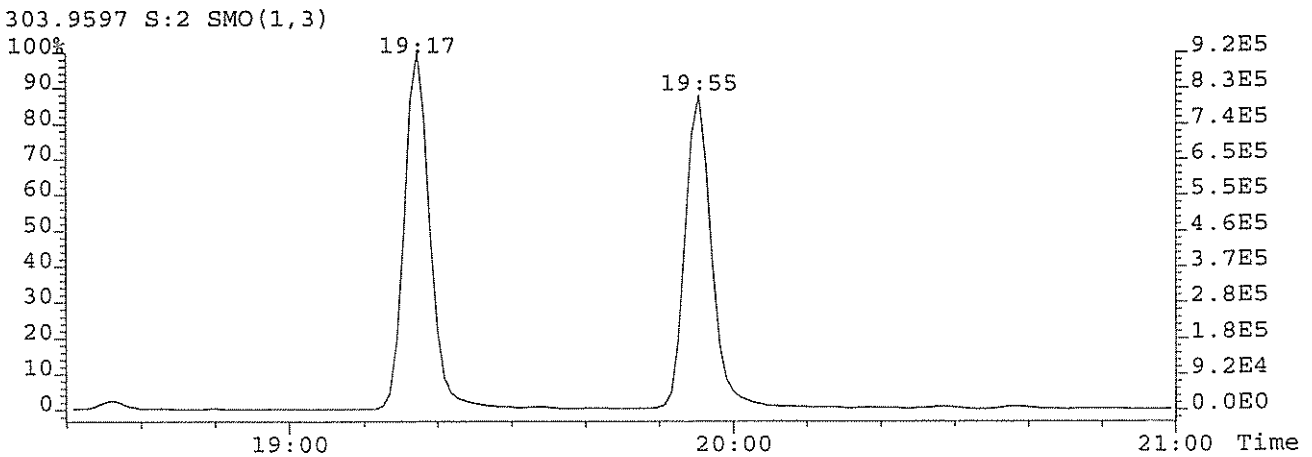
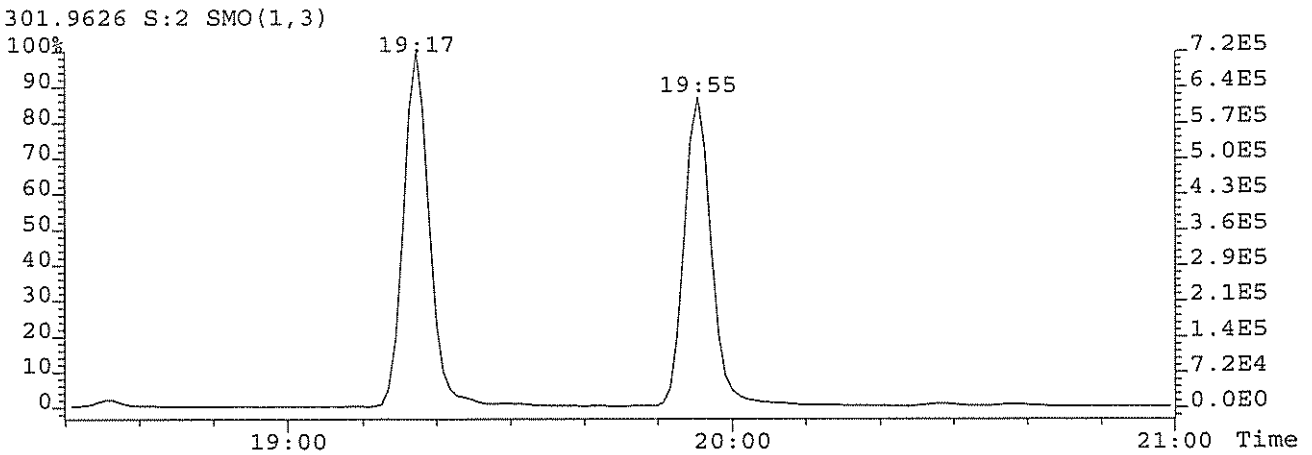
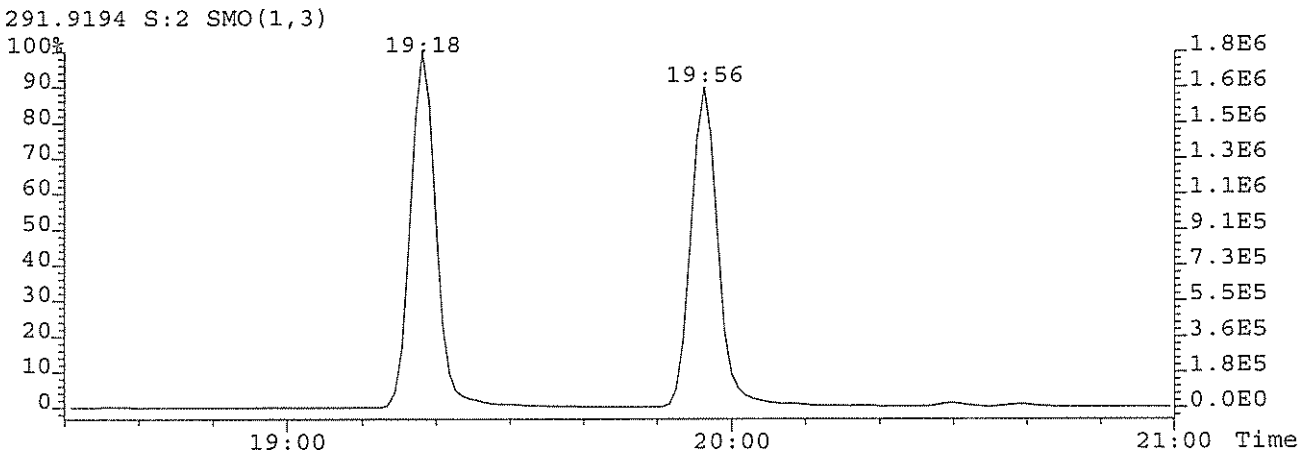
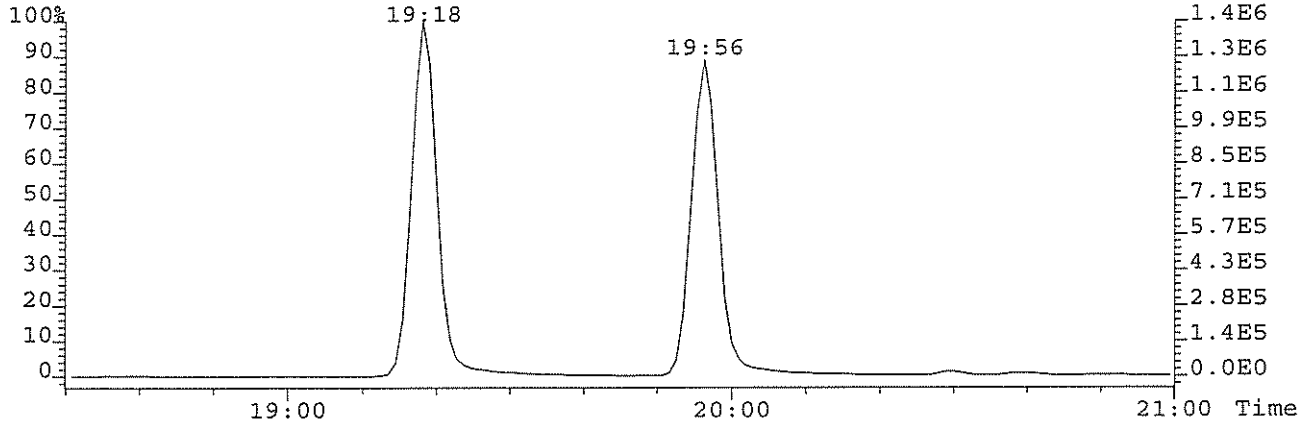


471.7750 S:2 F:3 SMO(1,3)



PCDDsクロマトグラム (12)  
(OCDD)

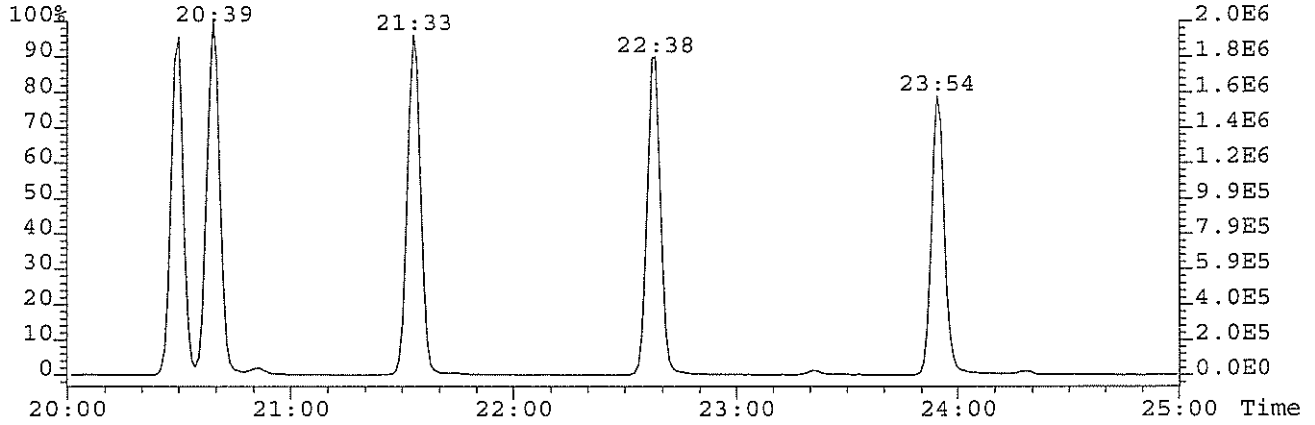
File:130716 #1-1430 Acq:16-JUL-2013 11:00:38 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22  
289.9224 S:2 SMO(1,3)



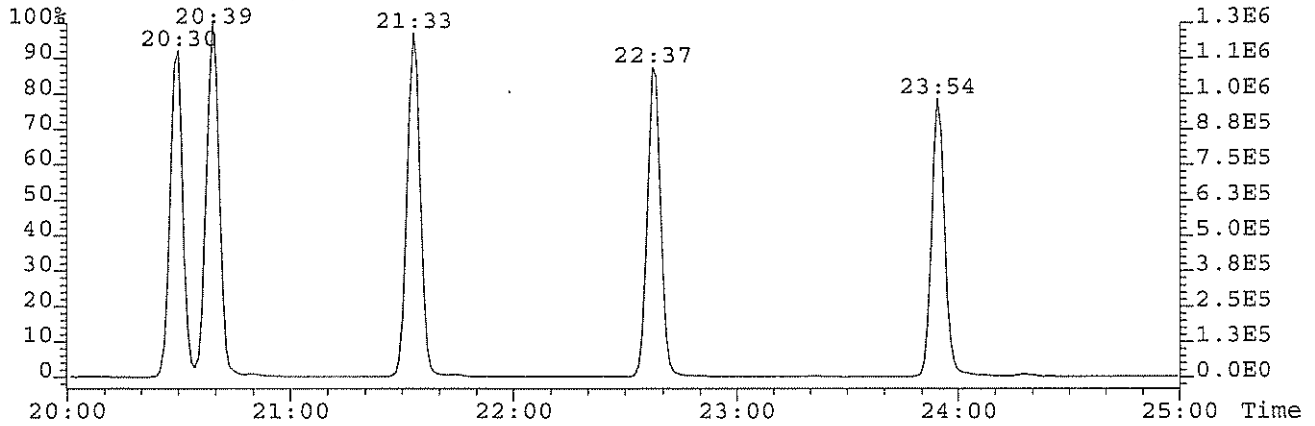
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130716 #1-1430 Acq:16-JUL-2013 11:00:38 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

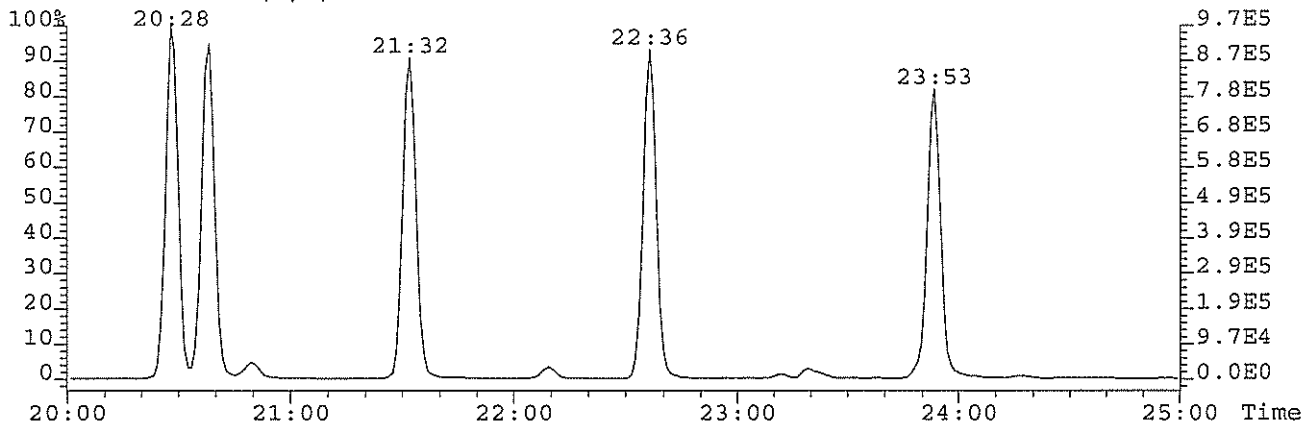
325.8804 S:2 SMO(1,3)



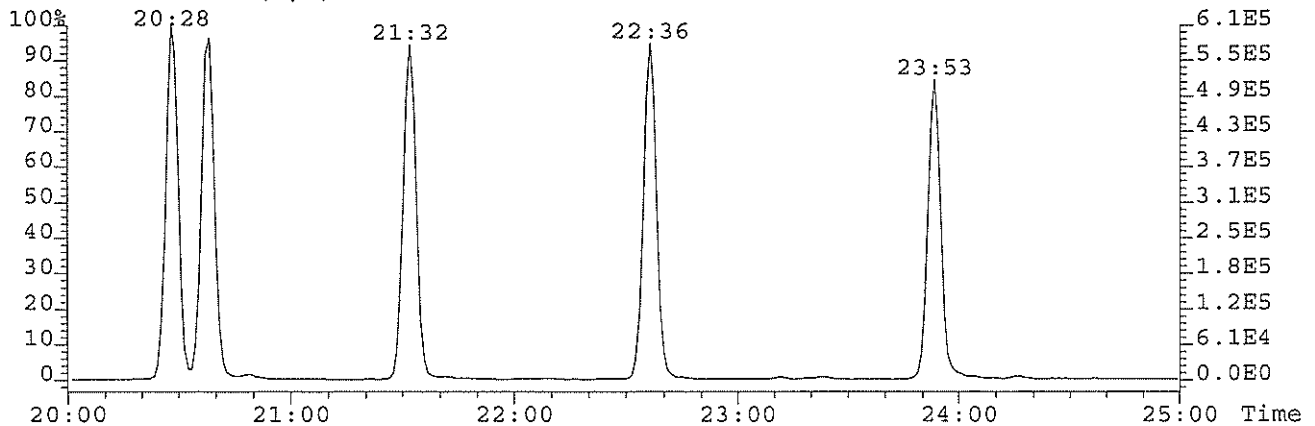
327.8775 S:2 SMO(1,3)



337.9207 S:2 SMO(1,3)

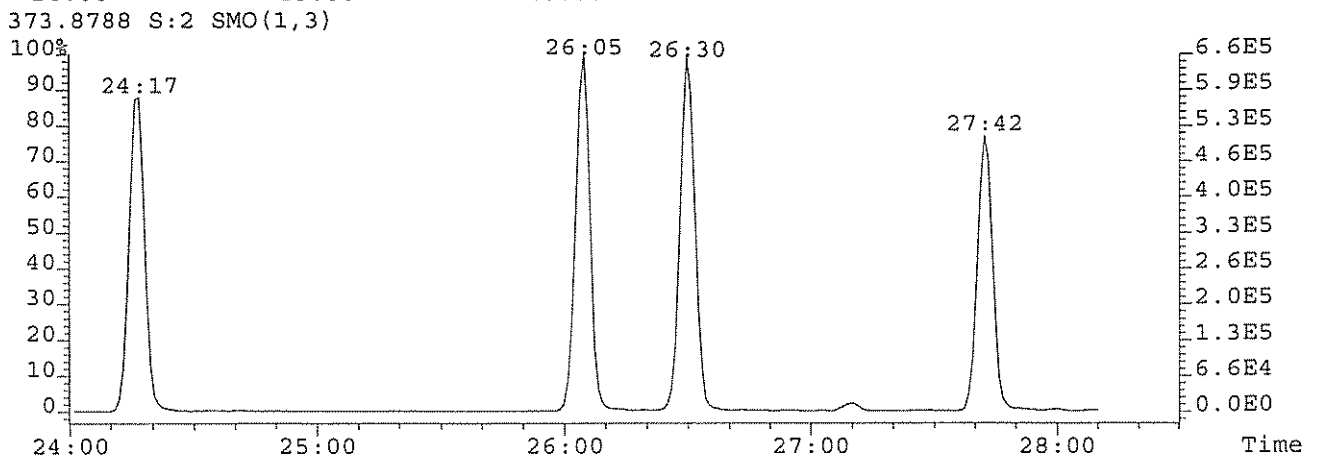
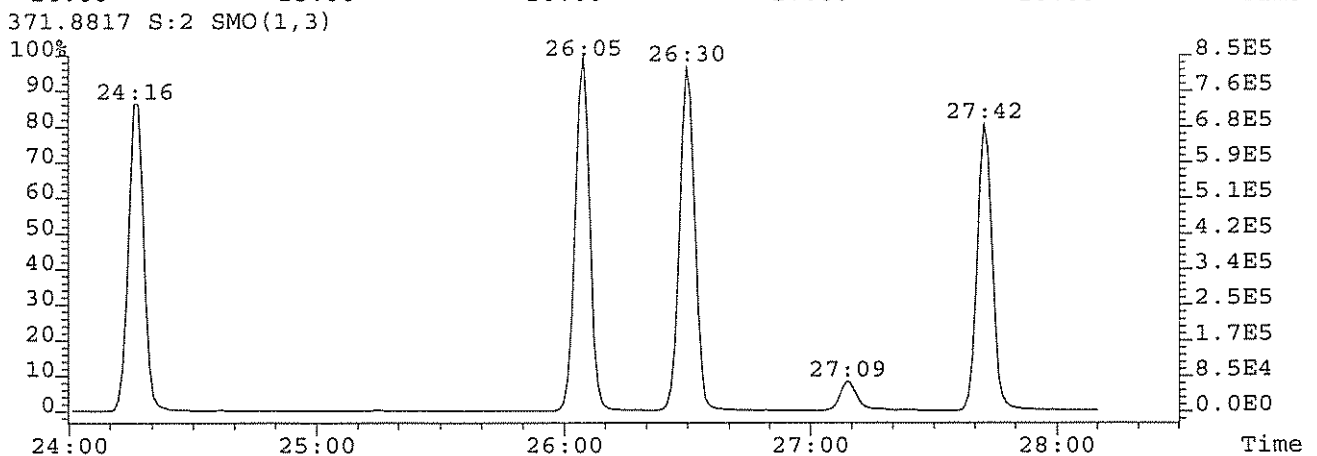
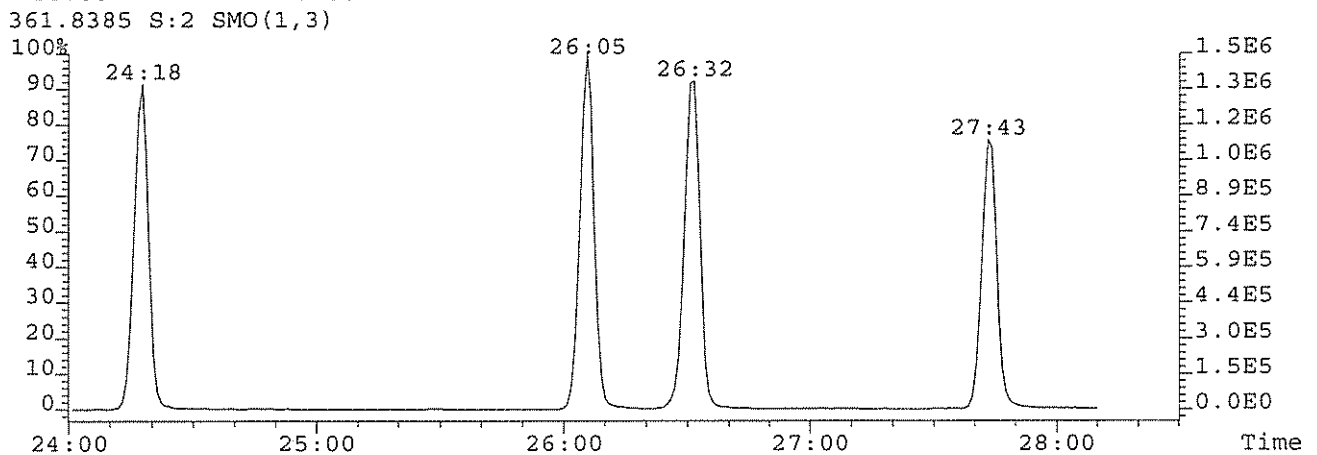
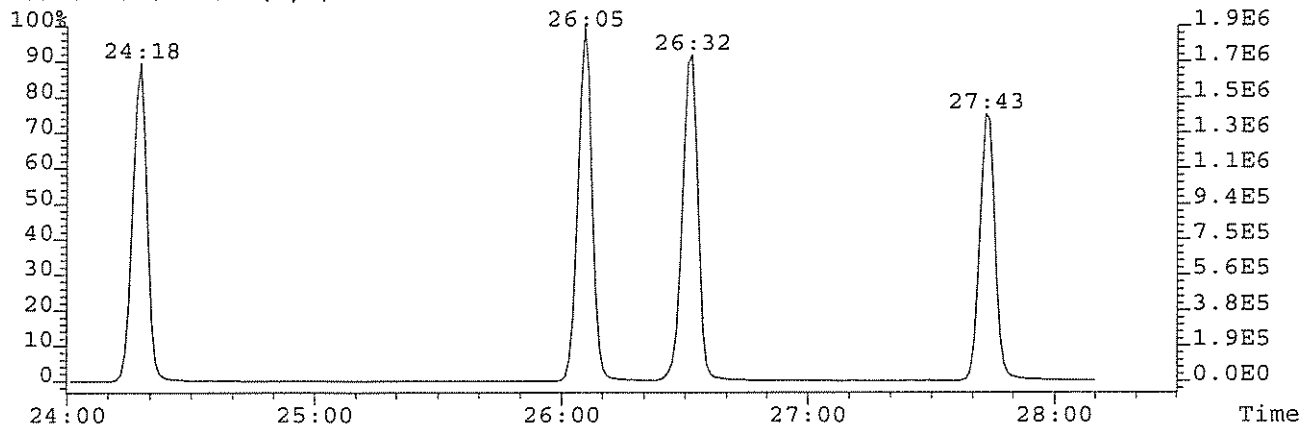


339.9178 S:2 SMO(1,3)



DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130716 #1-1430 Acq:16-JUL-2013 11:00:38 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22  
359.8415 S:2 SMO(1,3)

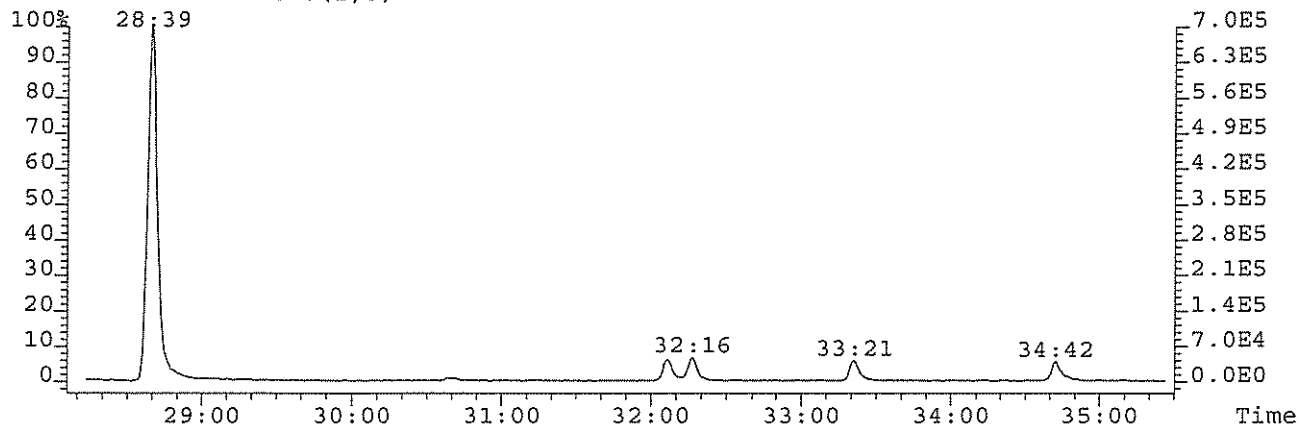


DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

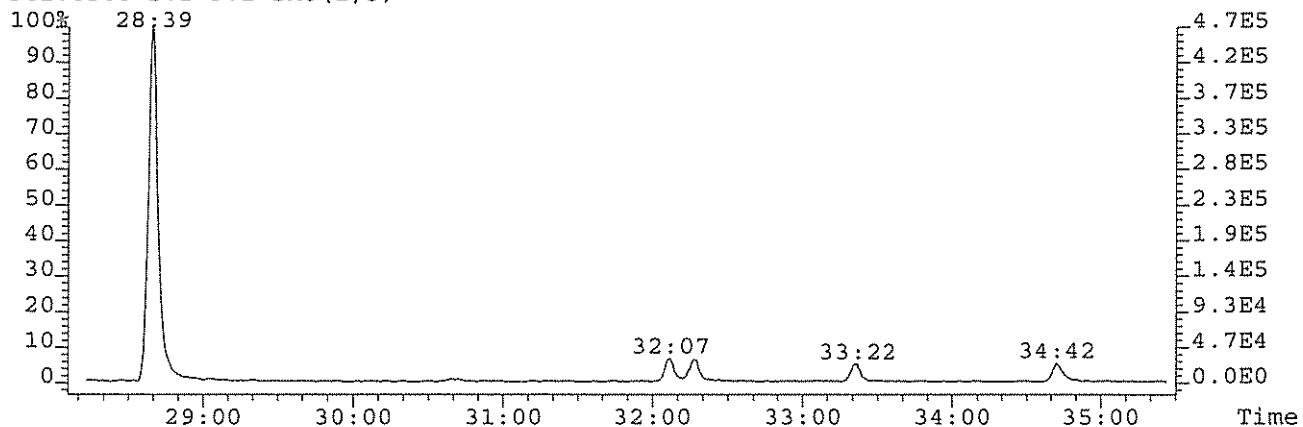
標準物質	
測定日	平成25年7月17日
測定物質	2,3,4,7,8-PeCDF, 1,2,3,7,8,9-HxCDF HpCDDs/DFs, OCDD/DFの同族体及び 2,3,7,8-位塩素置換異性体, Non-ortho PCB

File:130717 #1-648 Acq:17-JUL-2013 10:14:11 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

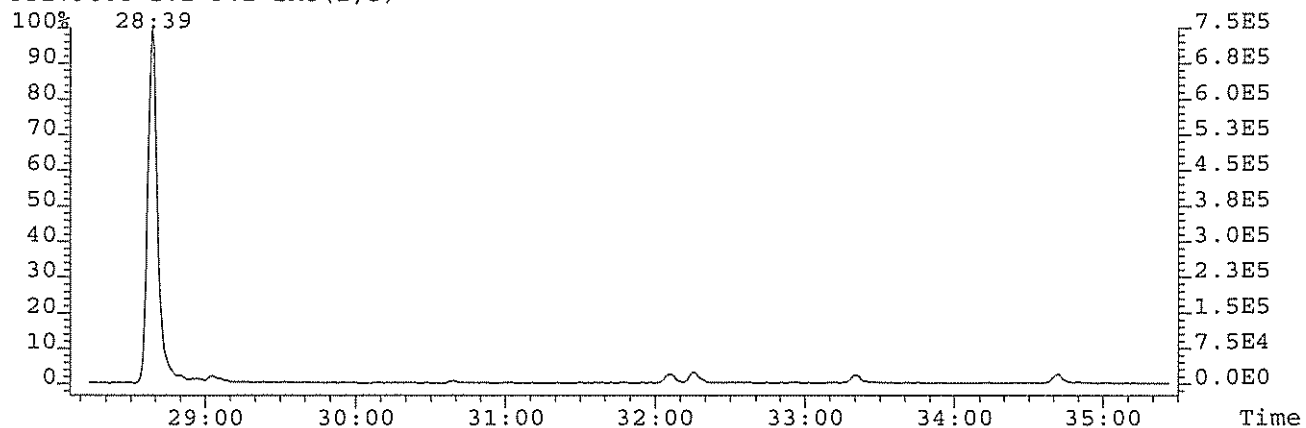
339.8597 S:2 F:2 SMO(1,3)



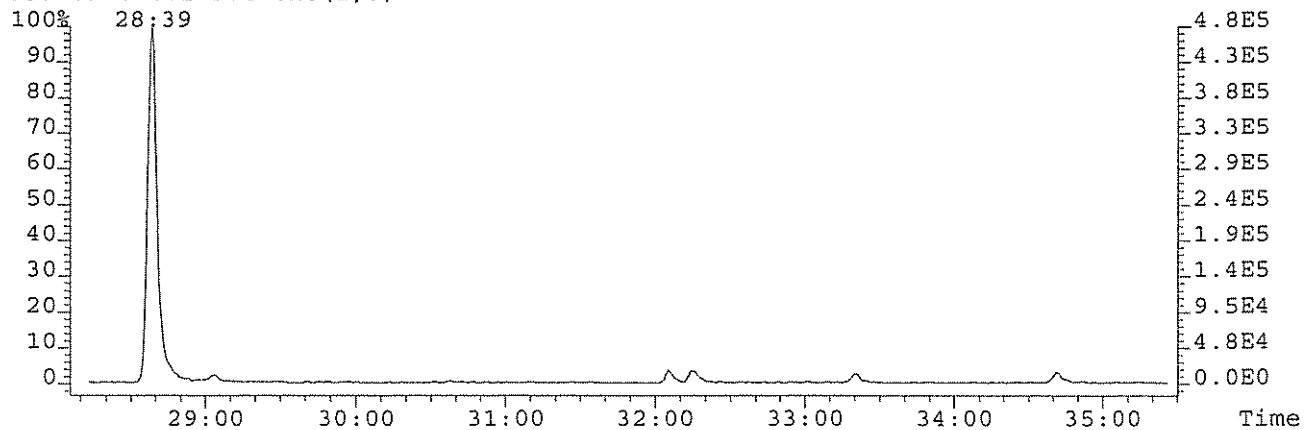
341.8568 S:2 F:2 SMO(1,3)



351.9000 S:2 F:2 SMO(1,3)



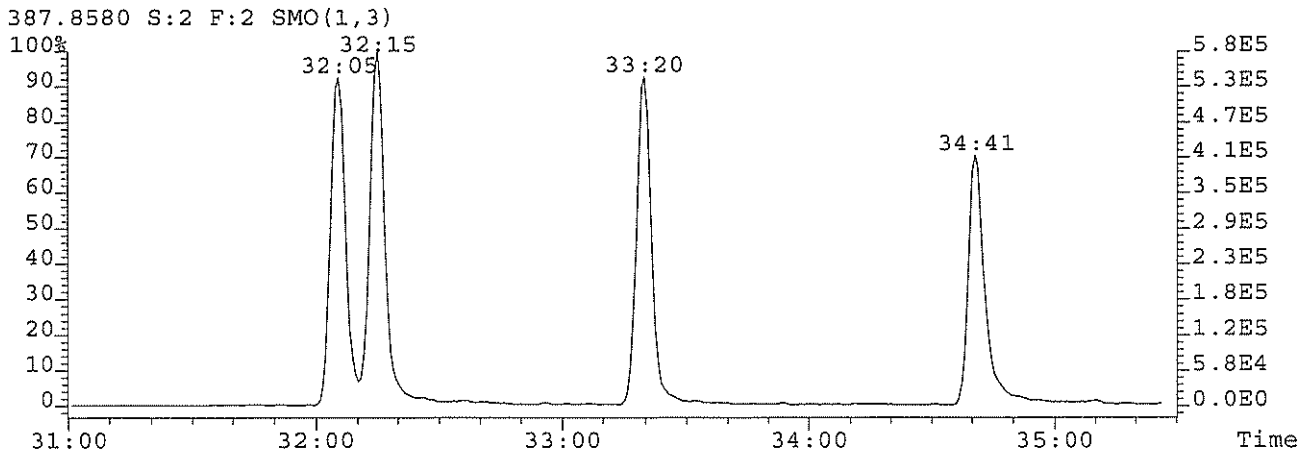
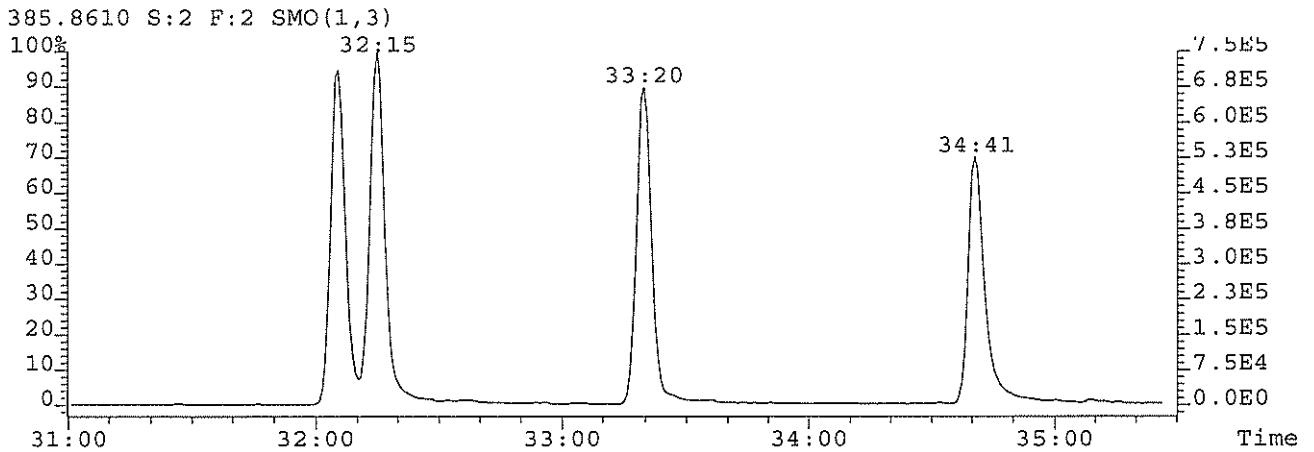
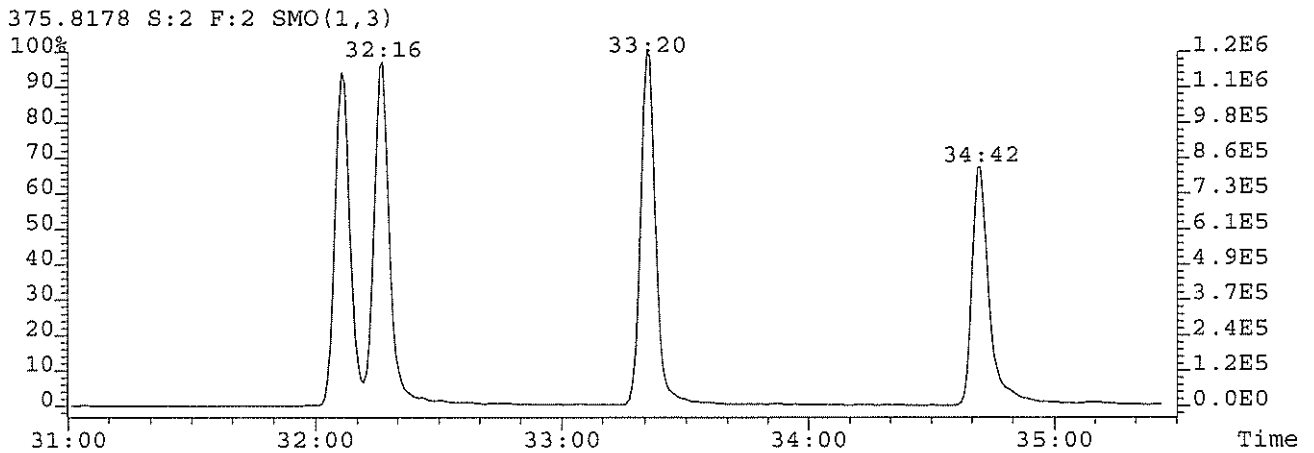
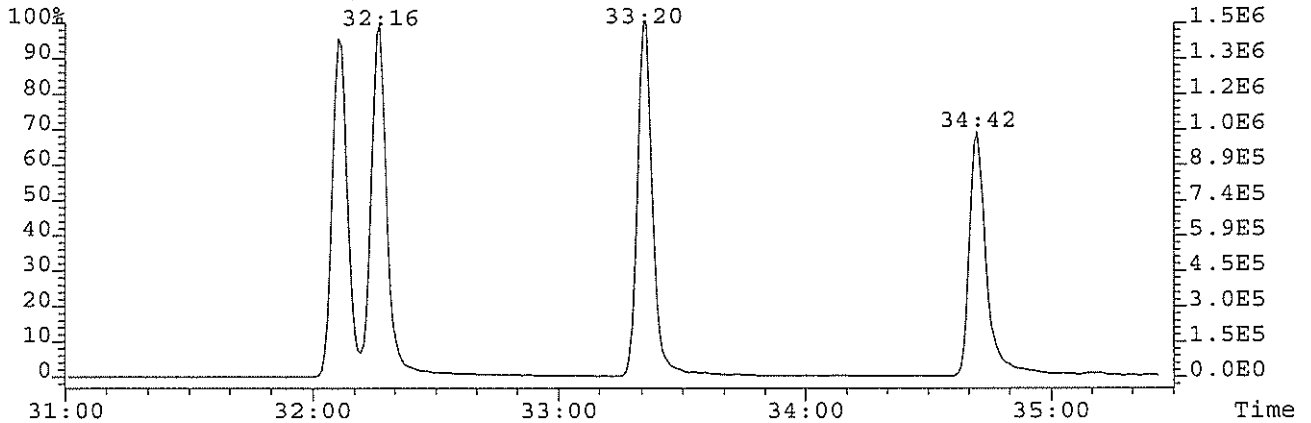
353.8970 S:2 F:2 SMO(1,3)



PeCDFsクロマトグラム (7)  
(23478-PeCDF)



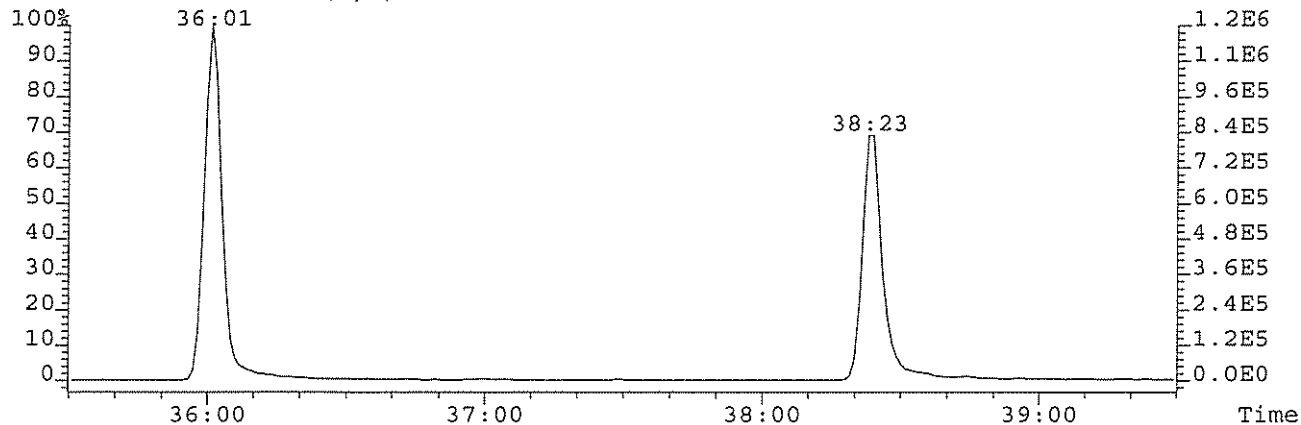
File:130717 #1-648 Acq:17-JUL-2013 10:14:11 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22  
373.8207 S:2 F:2 SMO(1,3)



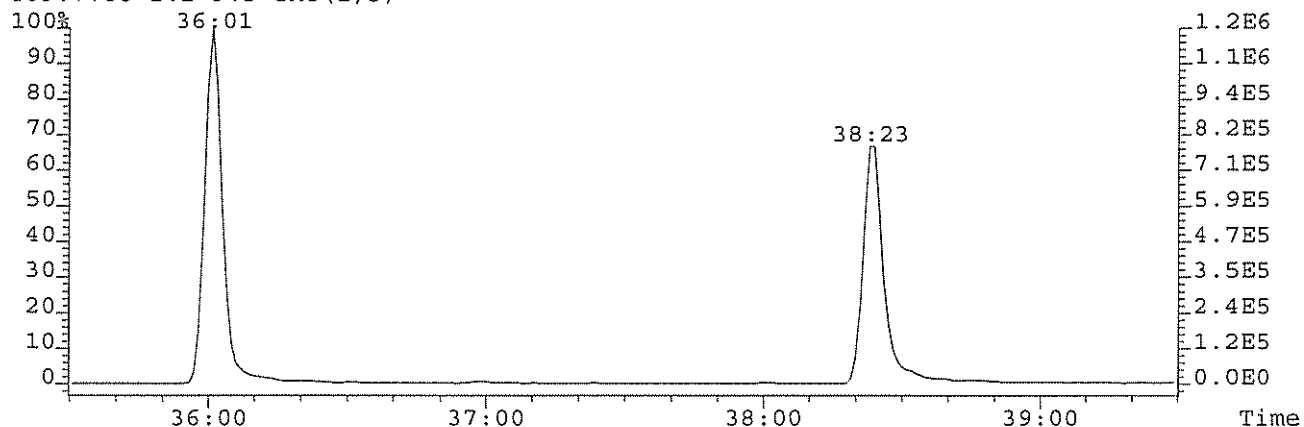
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130717 #1-562 Acq:17-JUL-2013 10:14:11 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

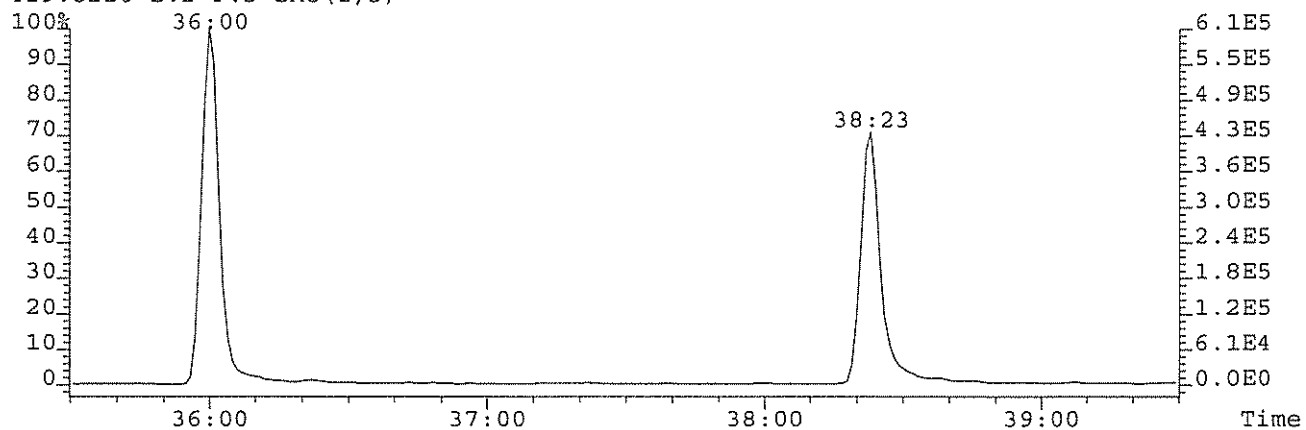
407.7818 S:2 F:3 SMO(1,3)



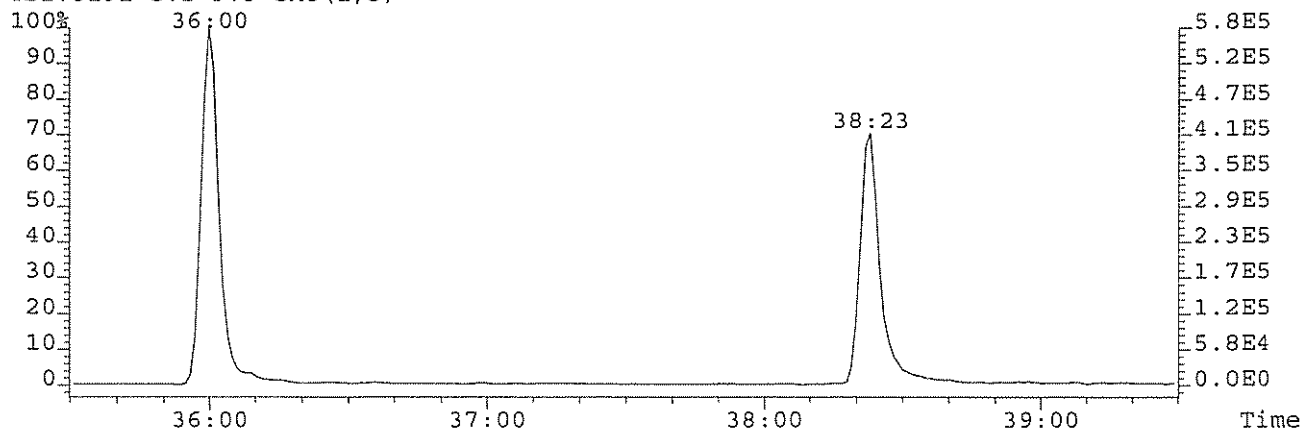
409.7788 S:2 F:3 SMO(1,3)



419.8220 S:2 F:3 SMO(1,3)



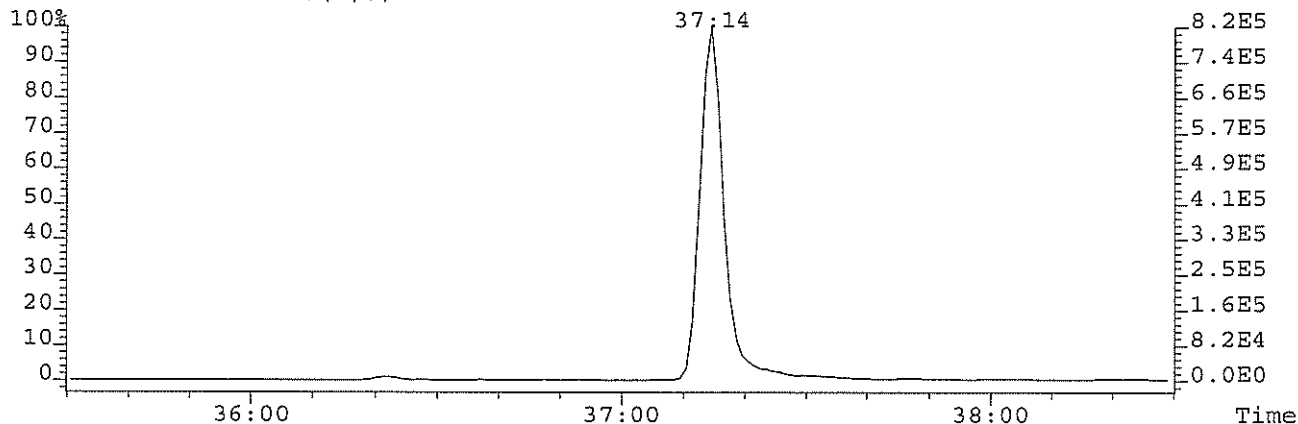
421.8191 S:2 F:3 SMO(1,3)



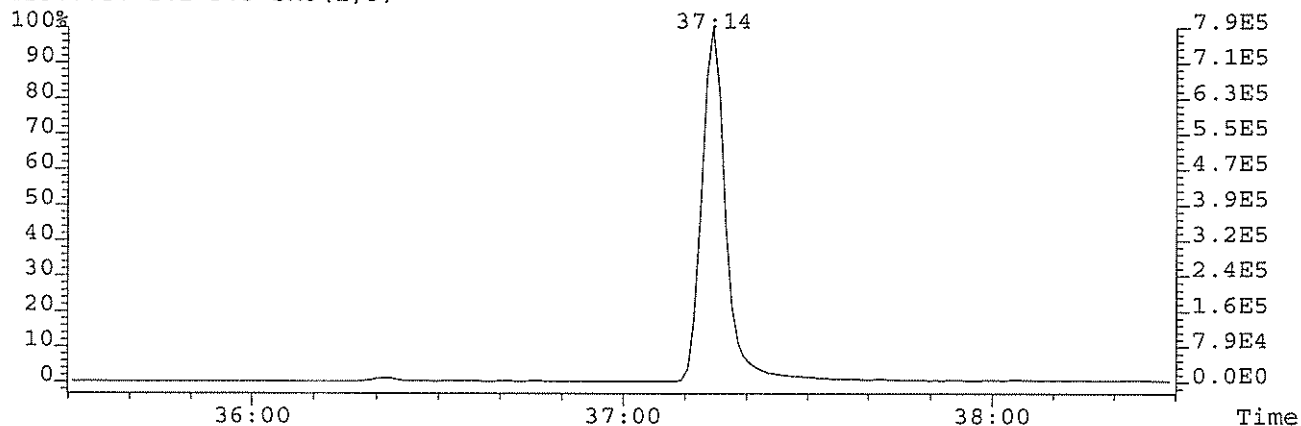
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130717 #1-562 Acq:17-JUL-2013 10:14:11 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

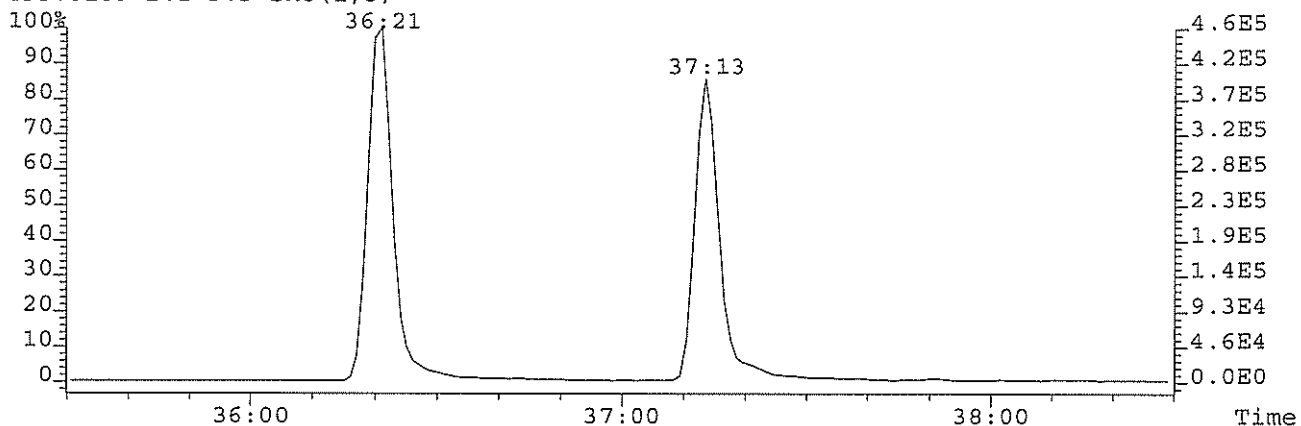
423.7767 S:2 F:3 SMO(1,3)



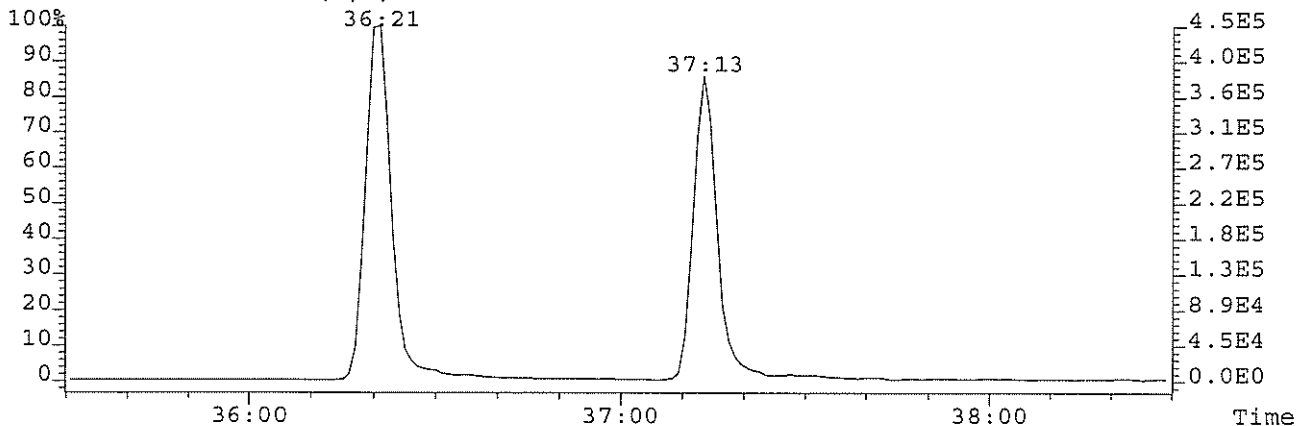
425.7737 S:2 F:3 SMO(1,3)



435.8169 S:2 F:3 SMO(1,3)



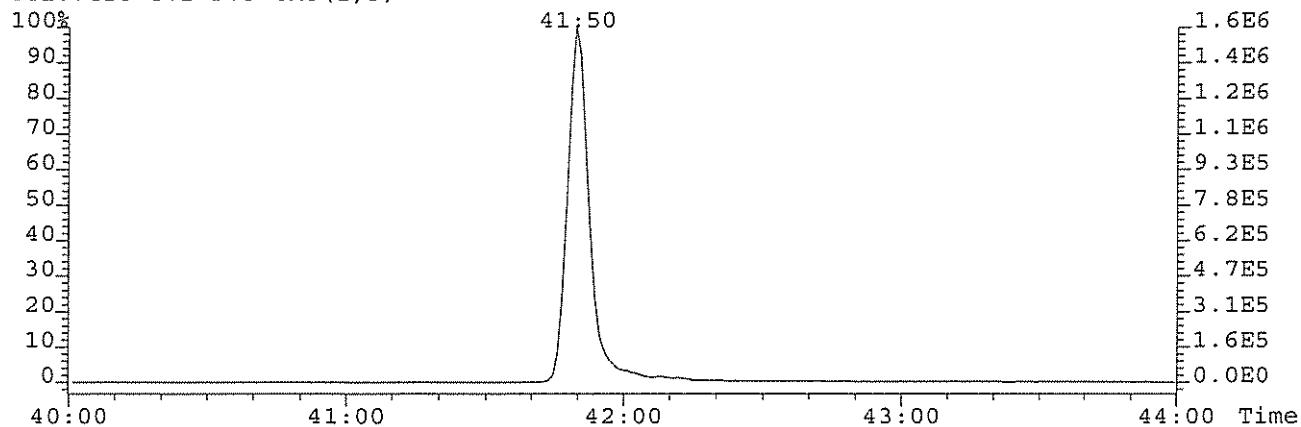
437.8140 S:2 F:3 SMO(1,3)



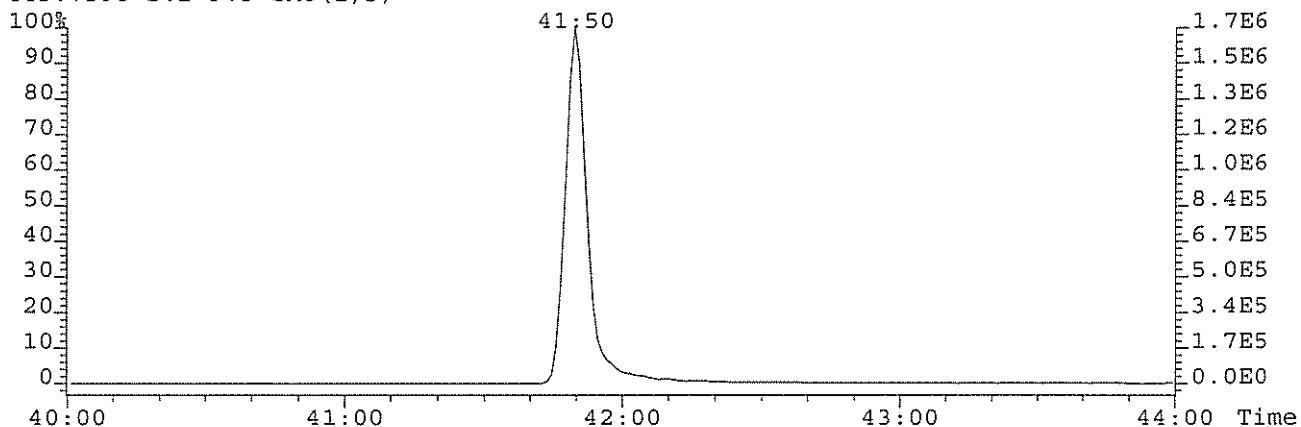
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130717 #1-562 Acq:17-JUL-2013 10:14:11 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

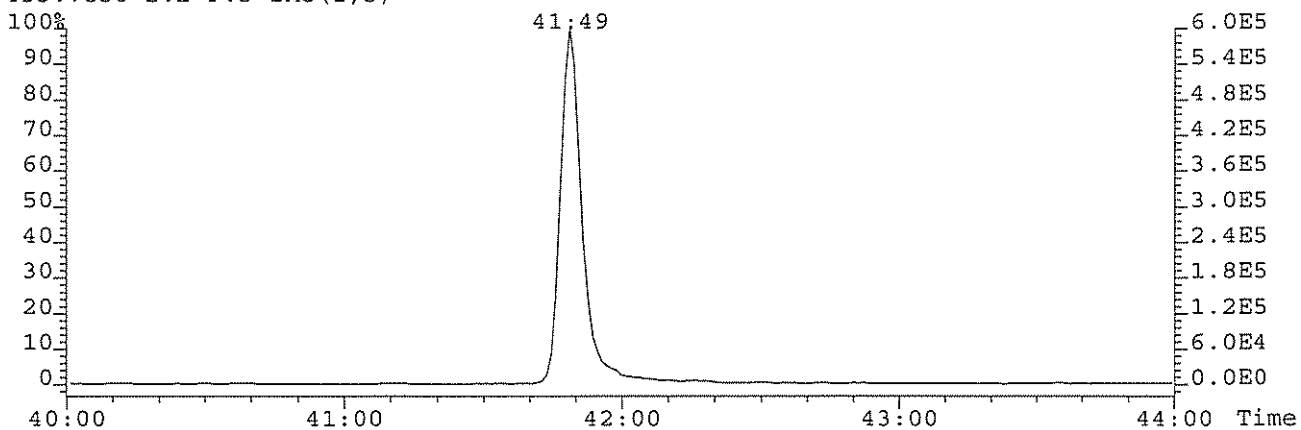
441.7428 S:2 F:3 SMO(1,3)



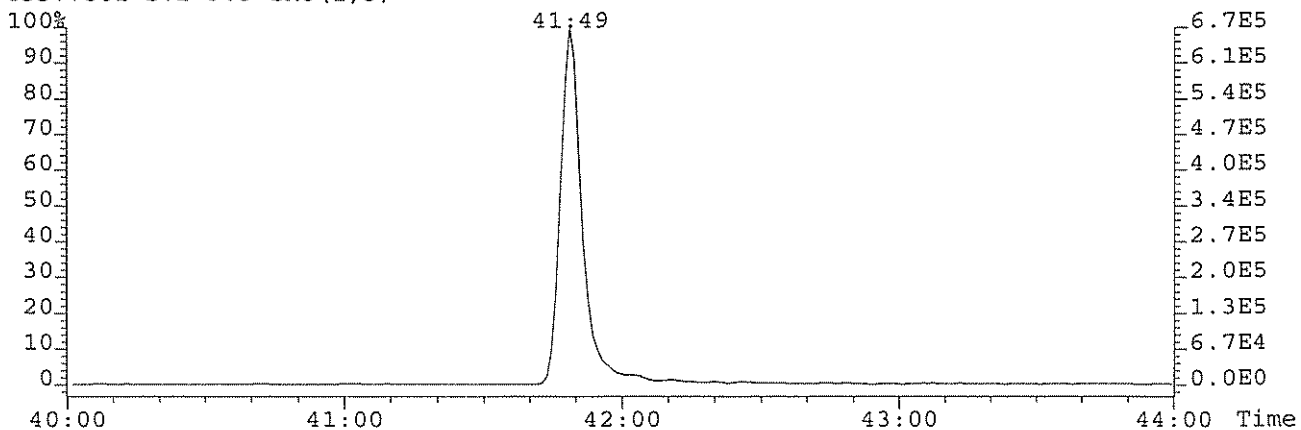
443.7398 S:2 F:3 SMO(1,3)



453.7830 S:2 F:3 SMO(1,3)



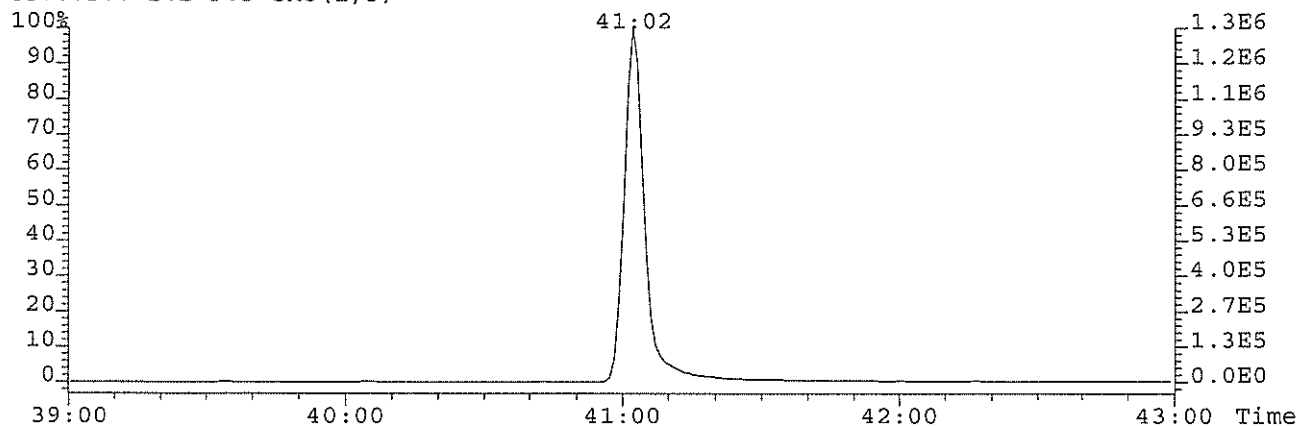
455.7801 S:2 F:3 SMO(1,3)



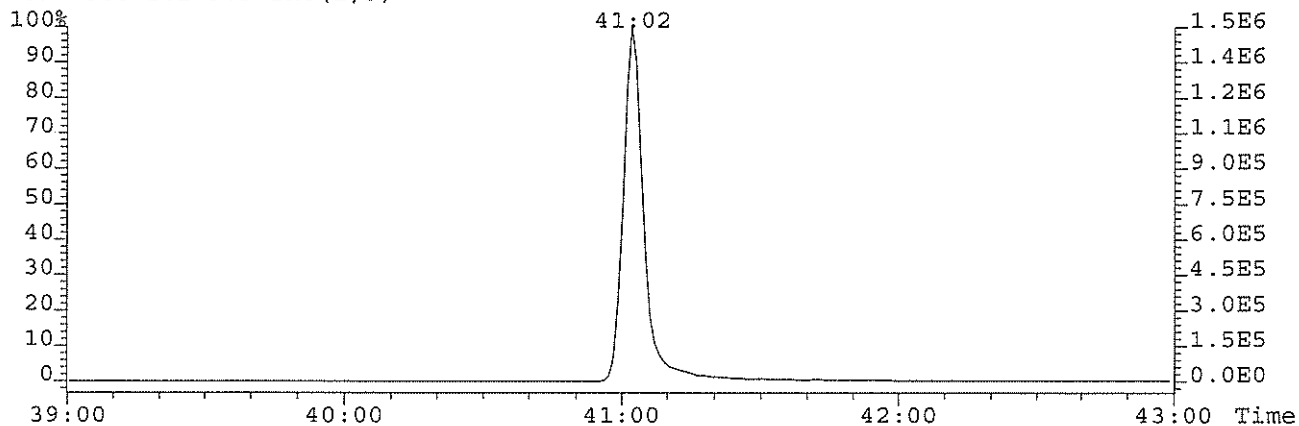
PCDFsクロマトグラム (11)  
(OCDF)

File:130717 #1-562 Acq:17-JUL-2013 10:14:11 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

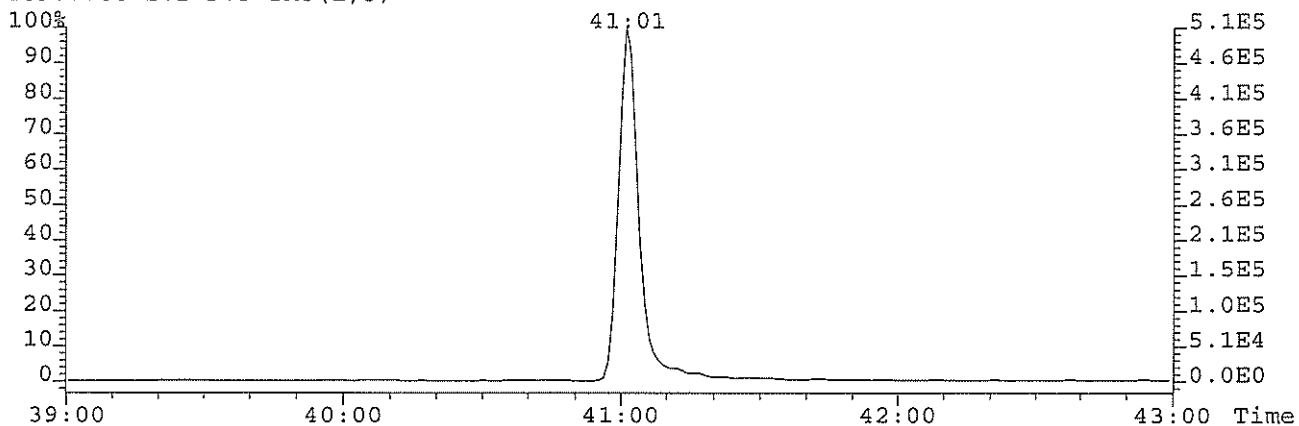
457.7377 S:2 F:3 SMO(1,3)



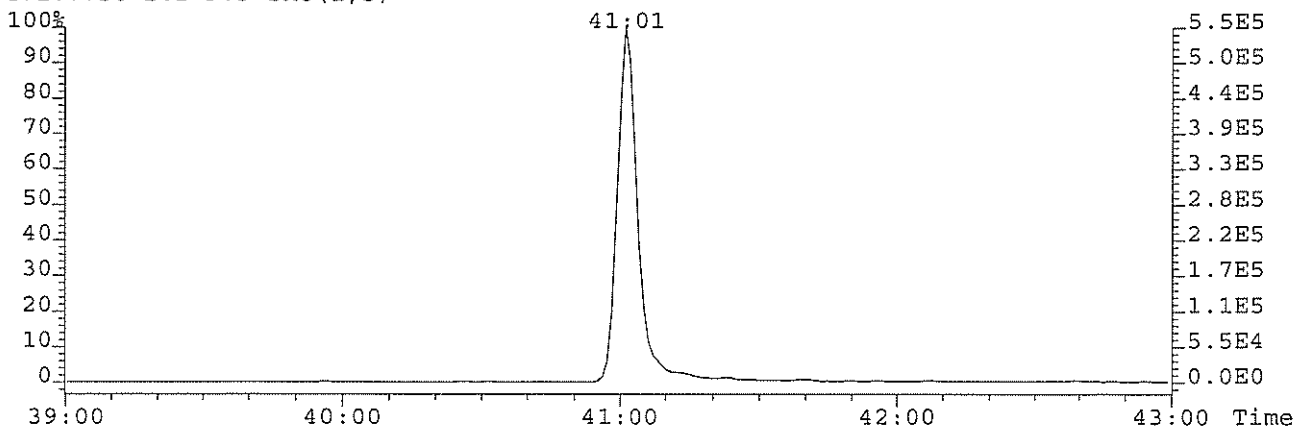
459.7348 S:2 F:3 SMO(1,3)



469.7780 S:2 F:3 SMO(1,3)

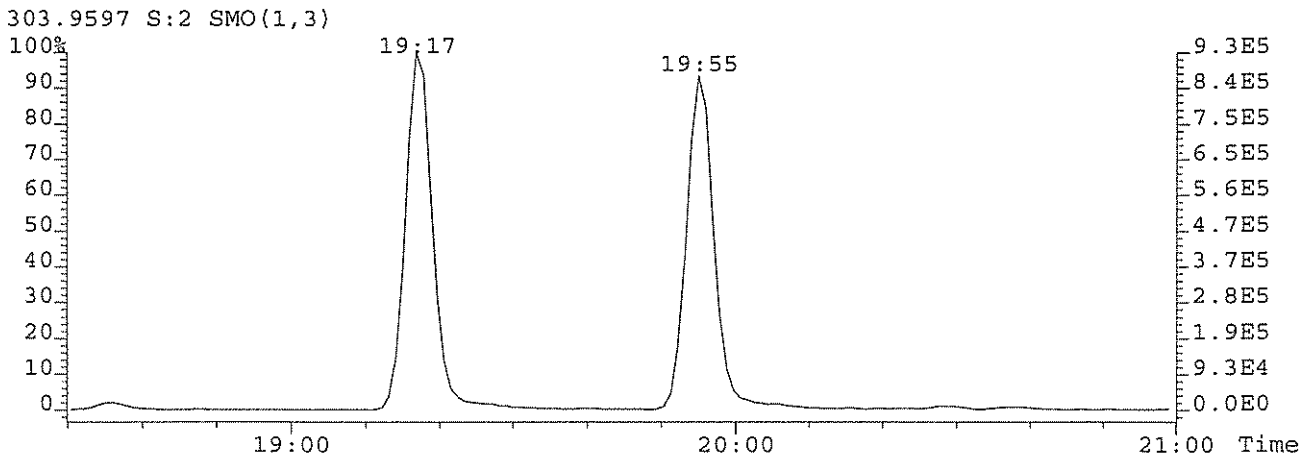
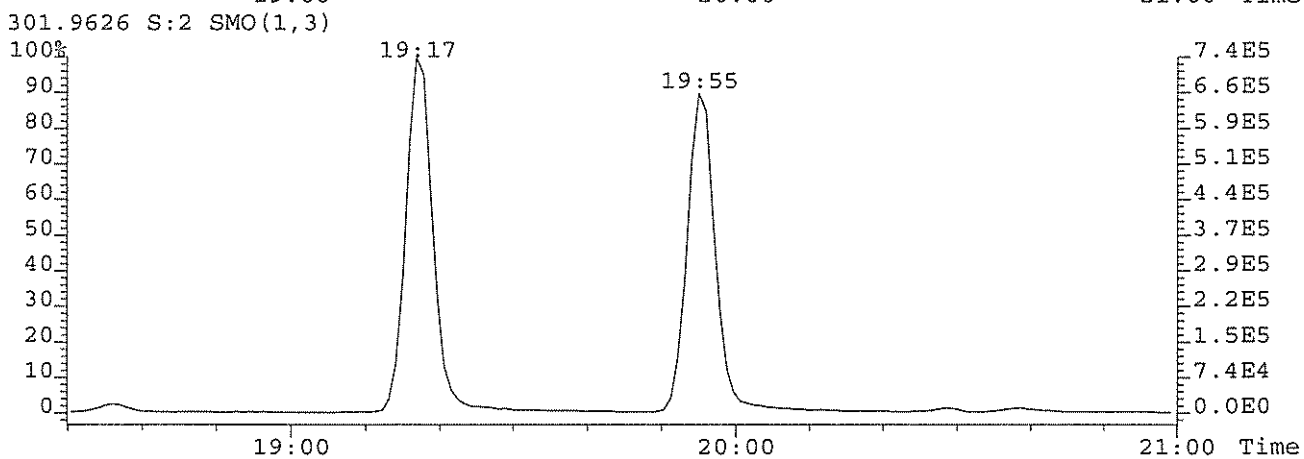
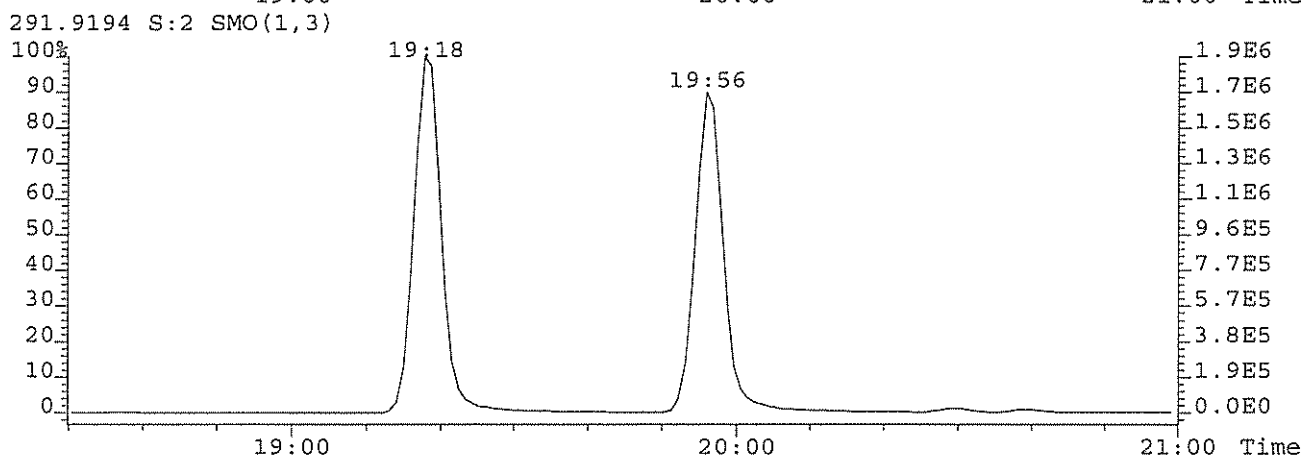
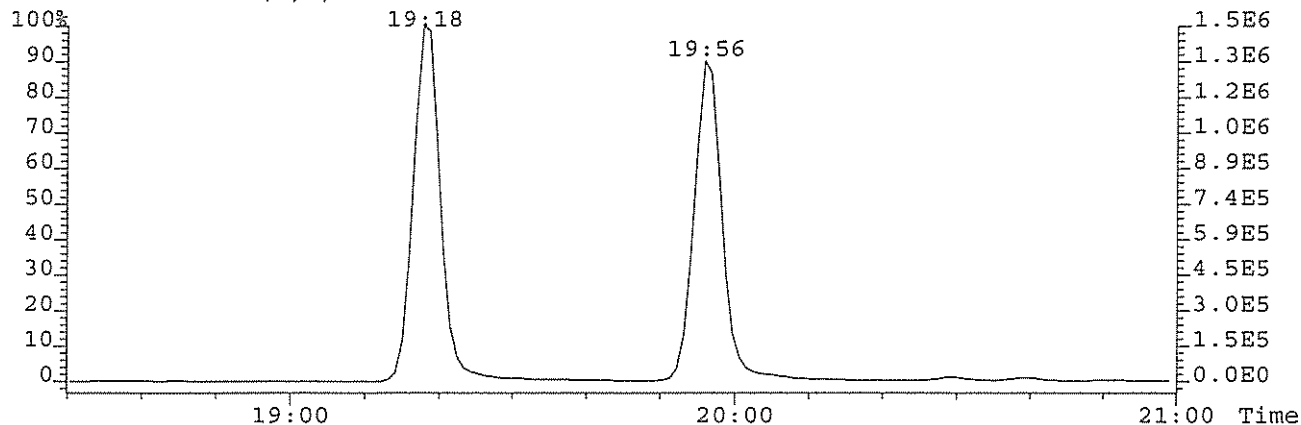


471.7750 S:2 F:3 SMO(1,3)



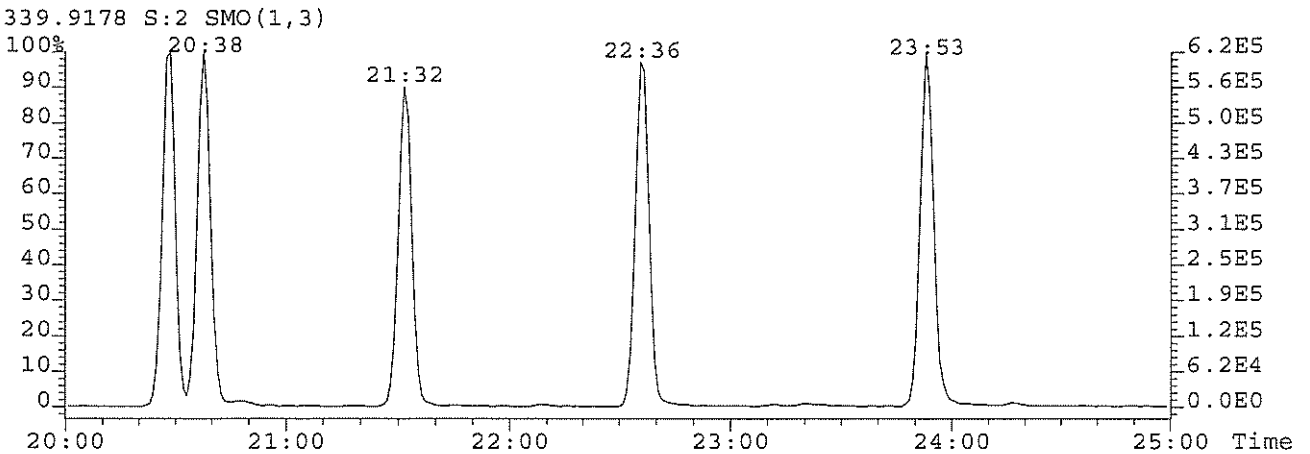
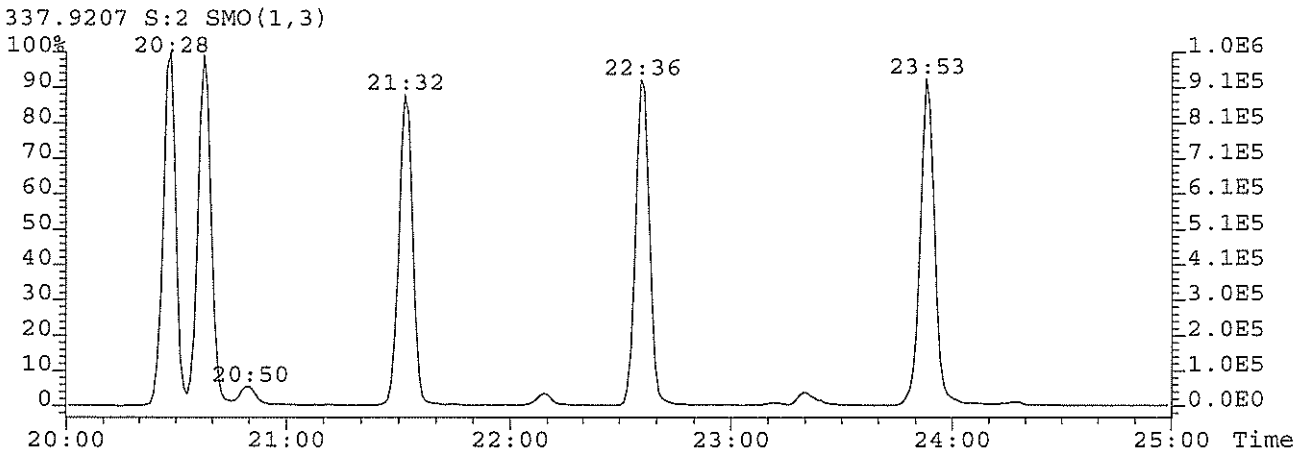
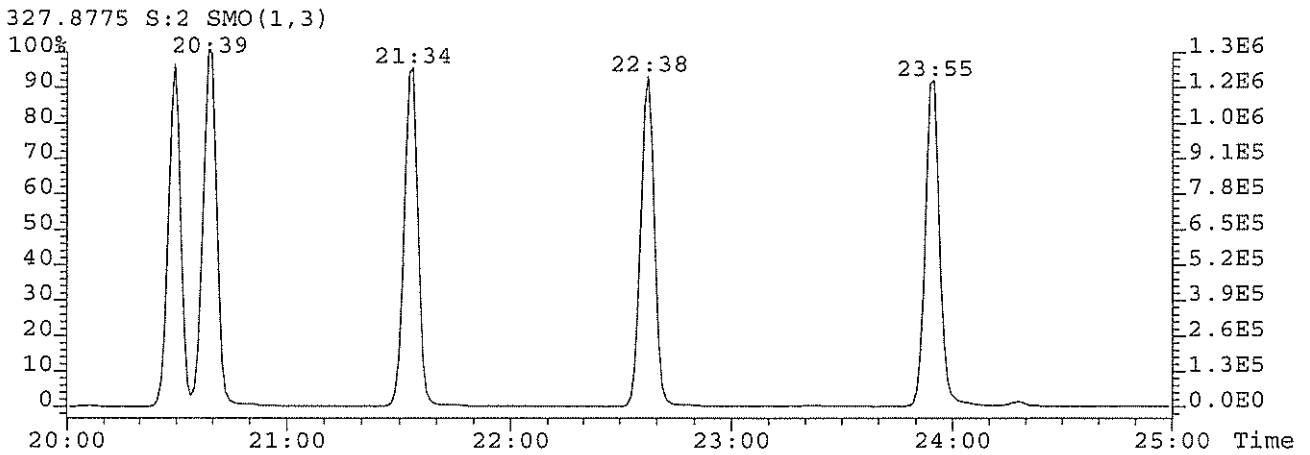
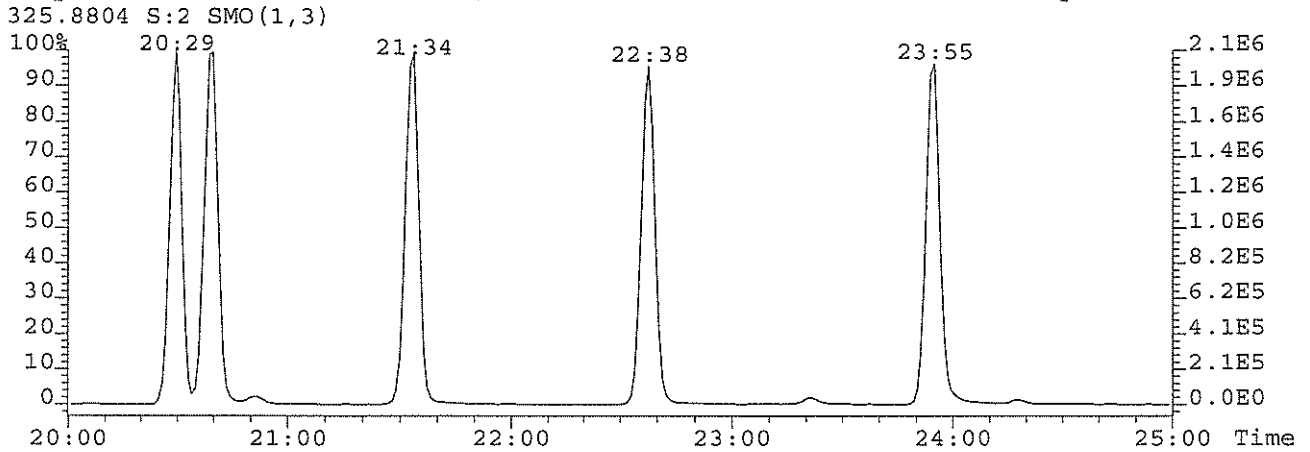
PCDDsクロマトグラム (12)  
(OCDD)

File:130717 #1-1430 Acq:17-JUL-2013 10:14:11 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22  
289.9224 S:2 SMO(1,3)



DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

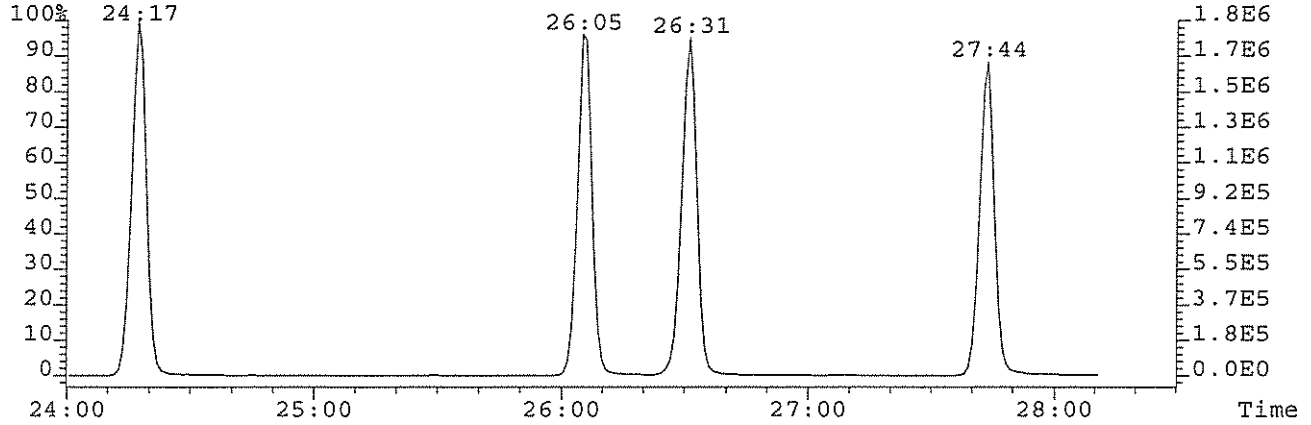
File:130717 #1-1430 Acq:17-JUL-2013 10:14:11 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22



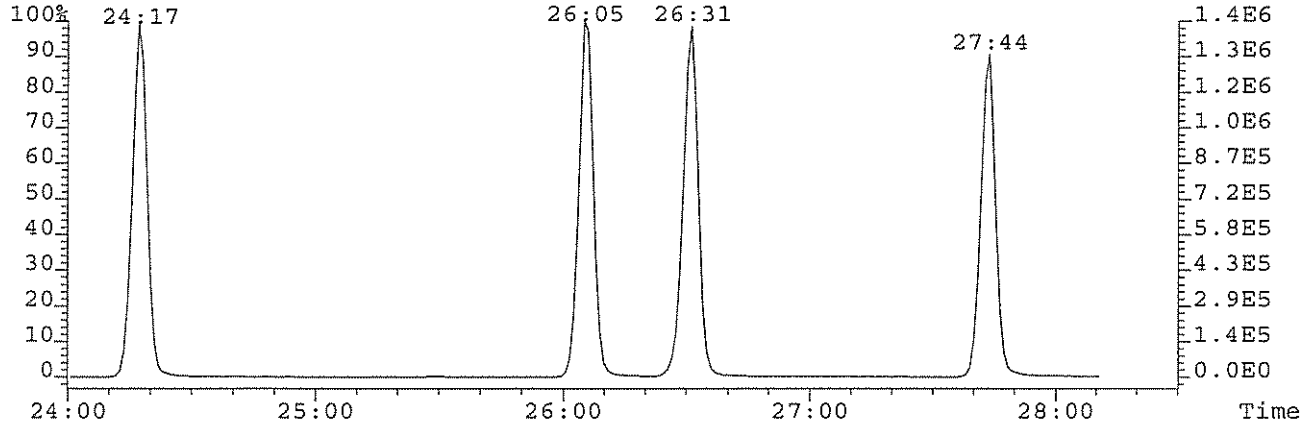
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130717 #1-1430 Acq:17-JUL-2013 10:14:11 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:DFP-STD3 Exp:RH-PD22

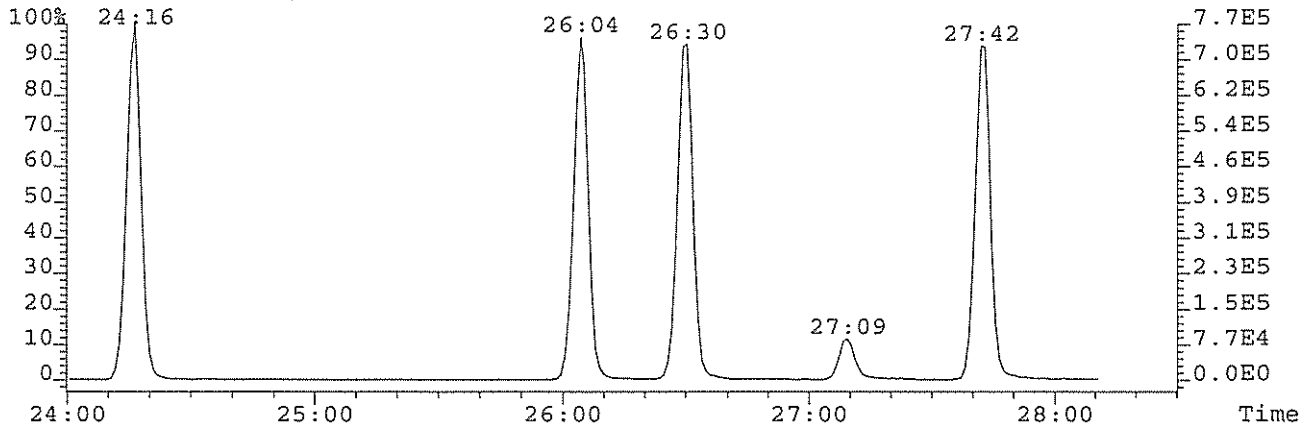
359.8415 S:2 SMO(1,3)



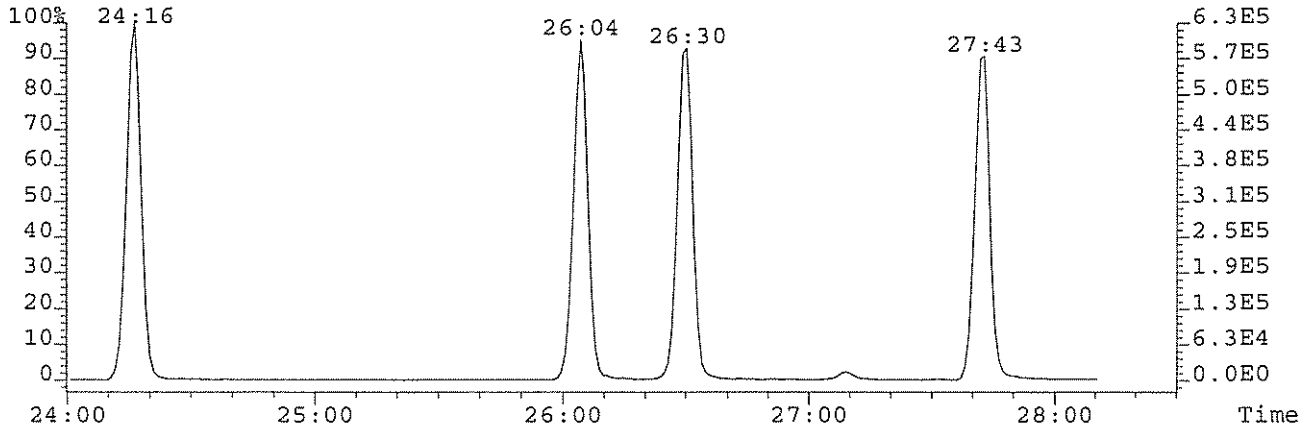
361.8385 S:2 SMO(1,3)



371.8817 S:2 SMO(1,3)



373.8788 S:2 SMO(1,3)

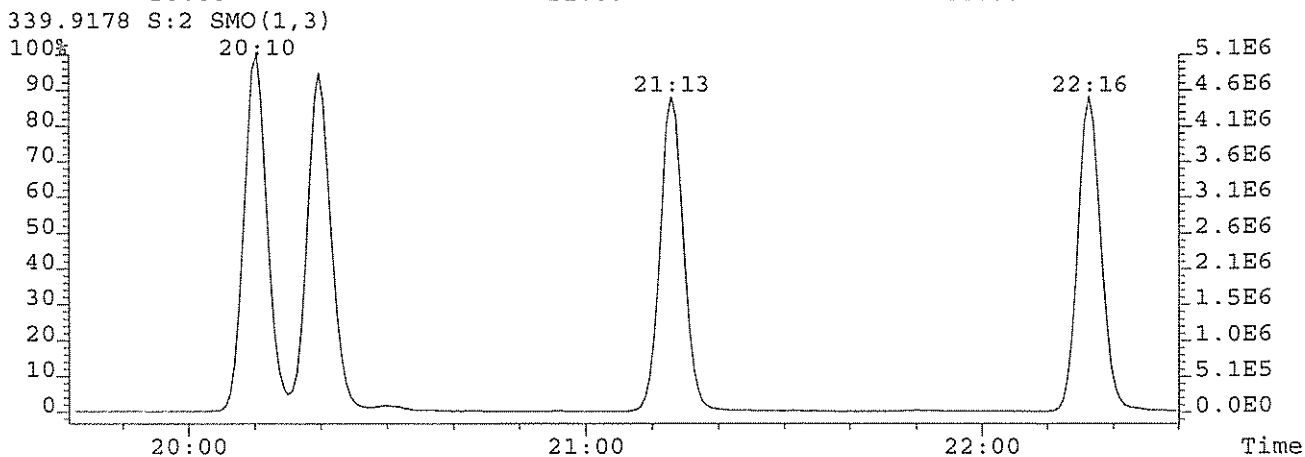
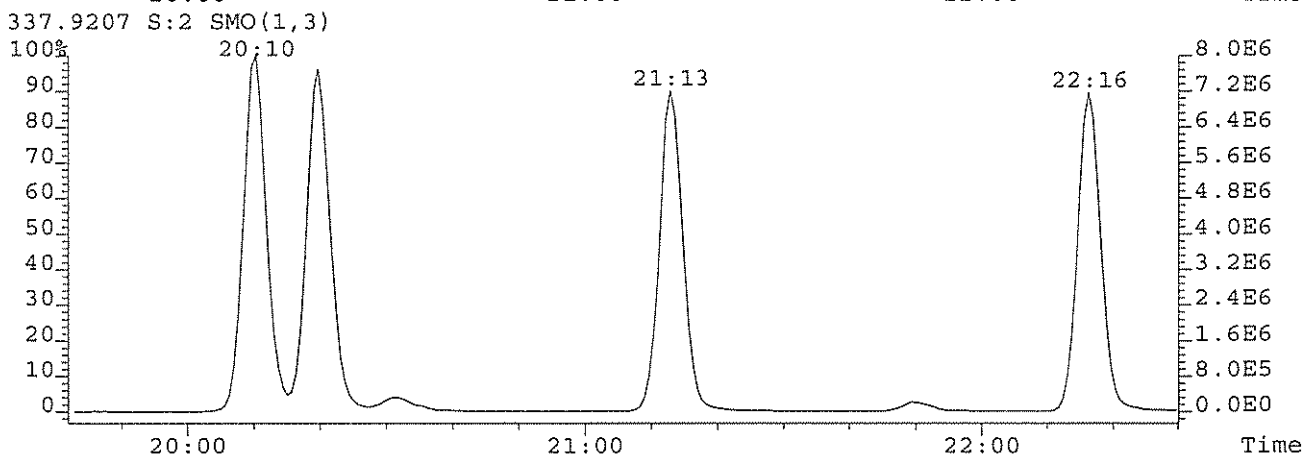
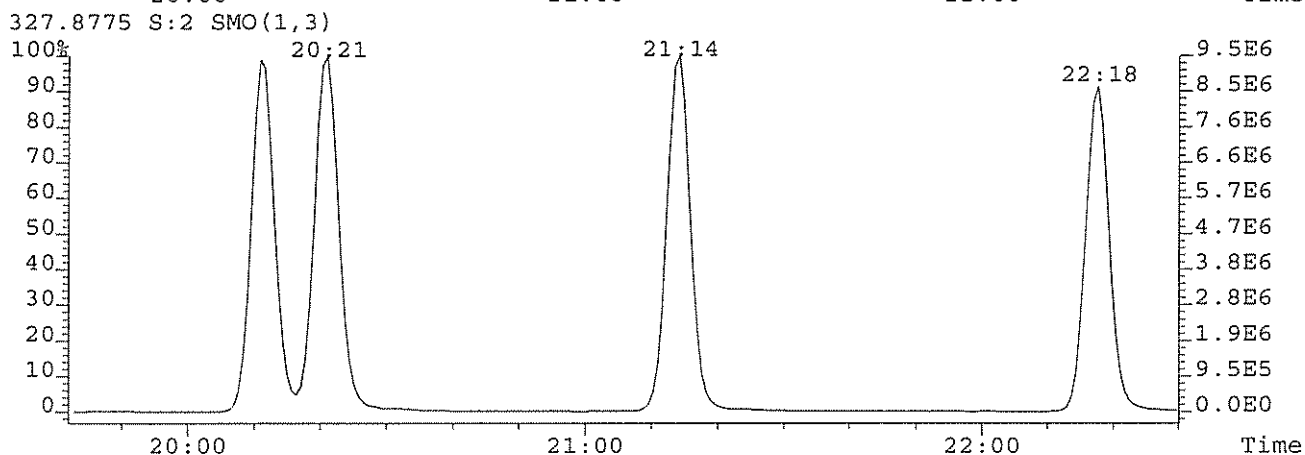
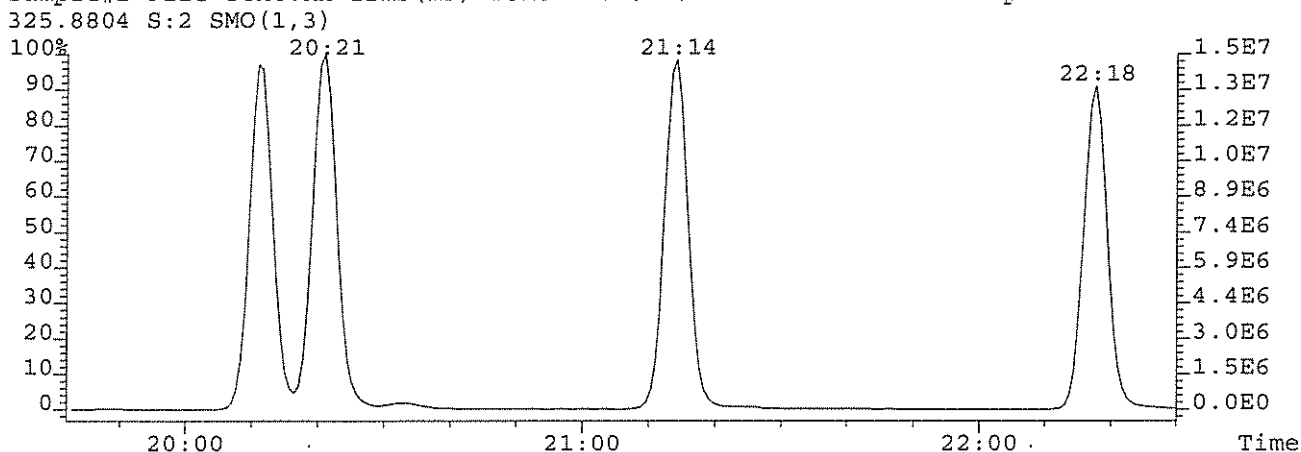


DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)



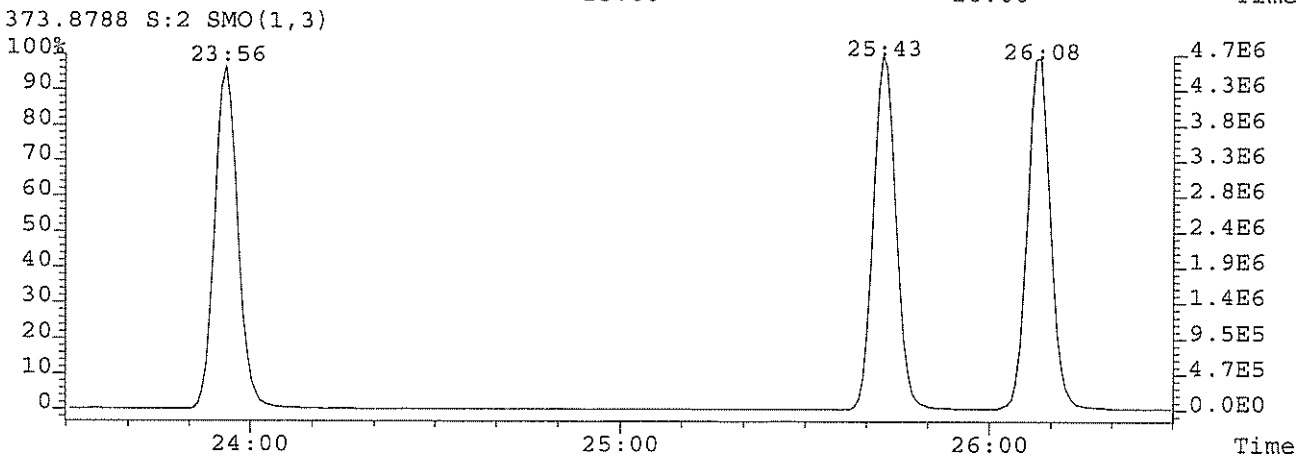
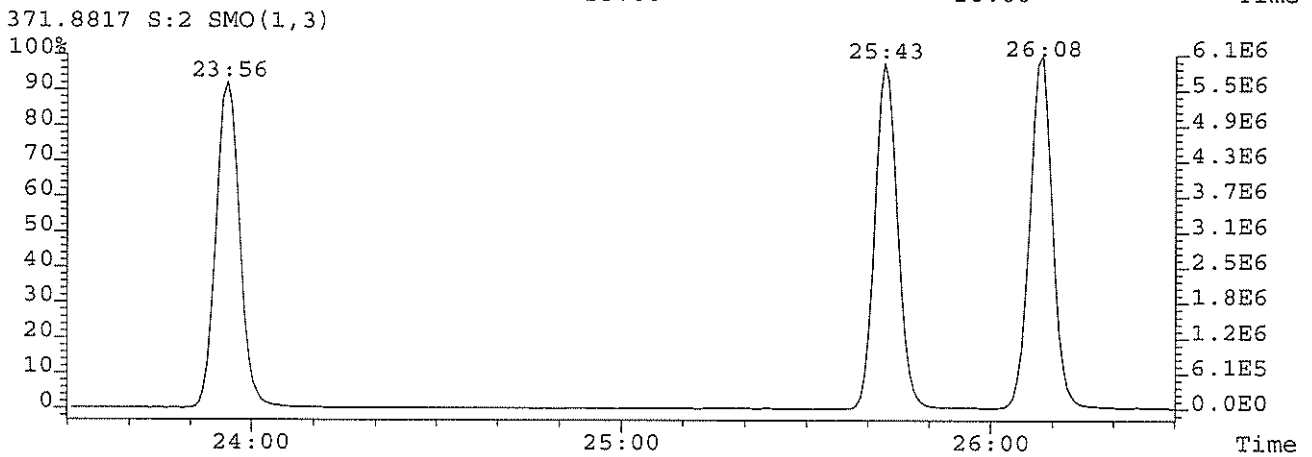
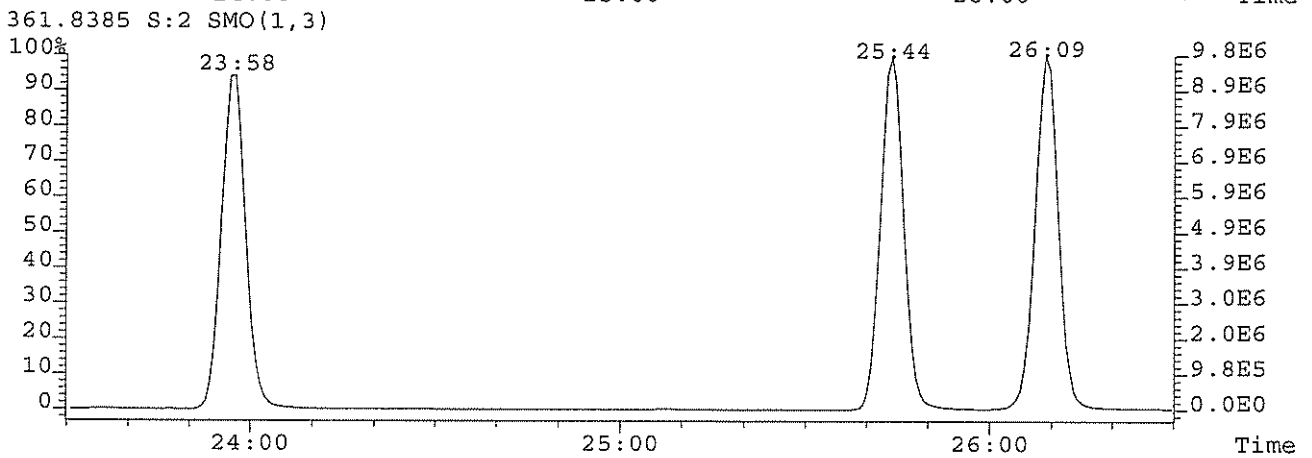
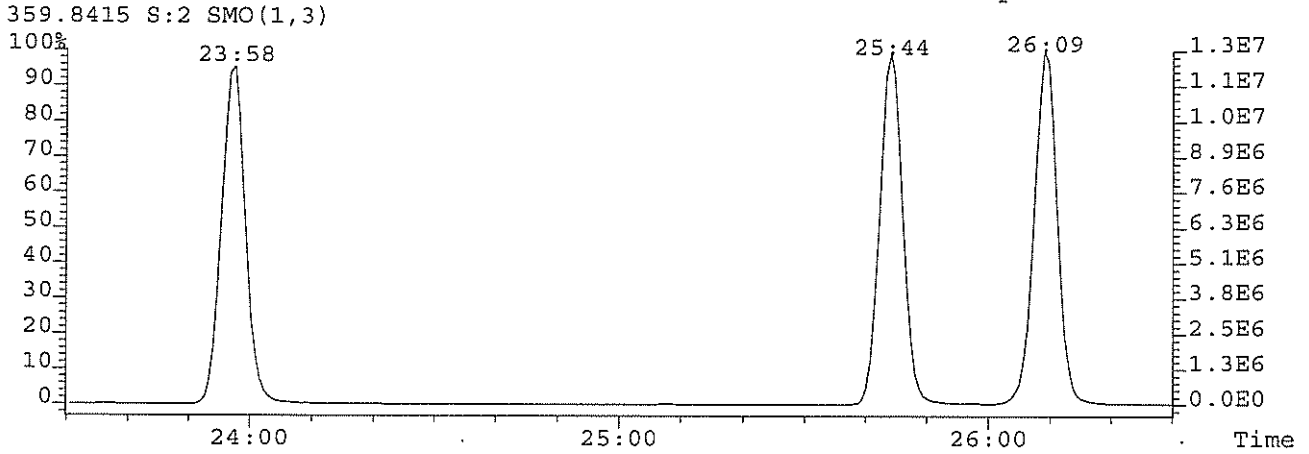
標準物質	
測定日	平成25年7月11日
測定物質	Mono-ortho PCB

File:130711 #1-2898 Acq:11-JUL-2013 11:40:49 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:DFP-STD3 Exp:RH-MP11



DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

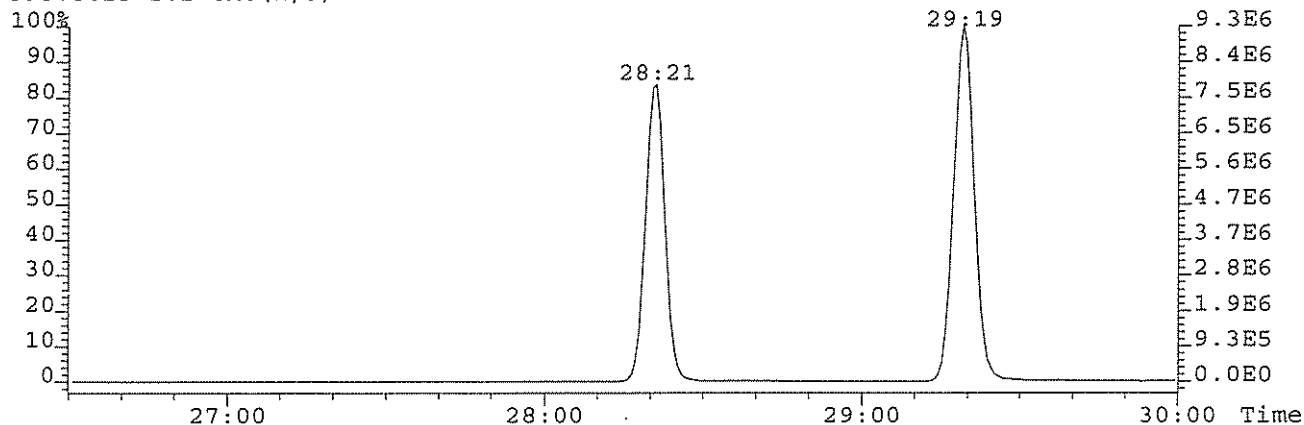
File:130711 #1-2898 Acq:11-JUL-2013 11:40:49 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:DFP-STD3 Exp:RH-MP11



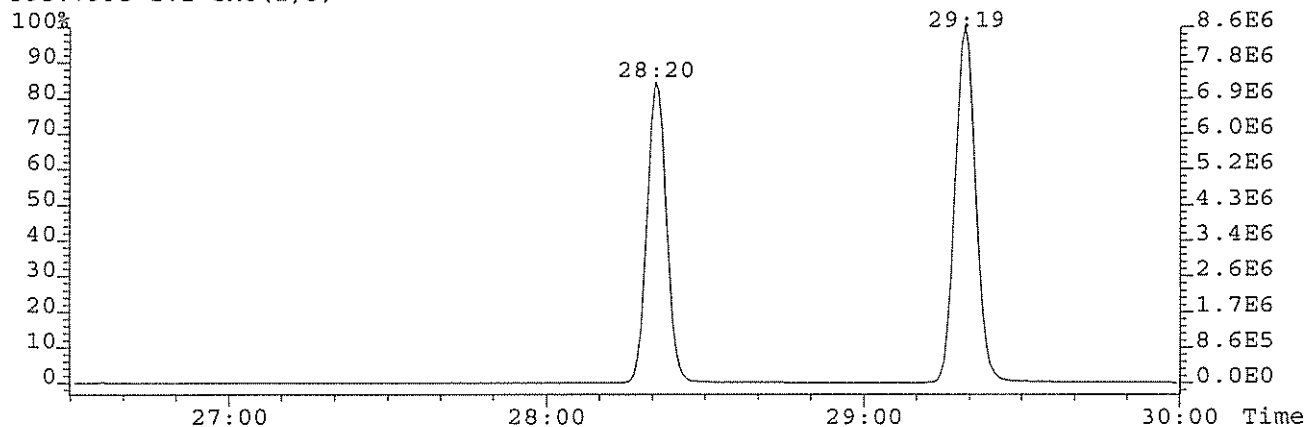
DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130711 #1-2898 Acq:11-JUL-2013 11:40:49 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:DFP-STD3 Exp:RH-MP11

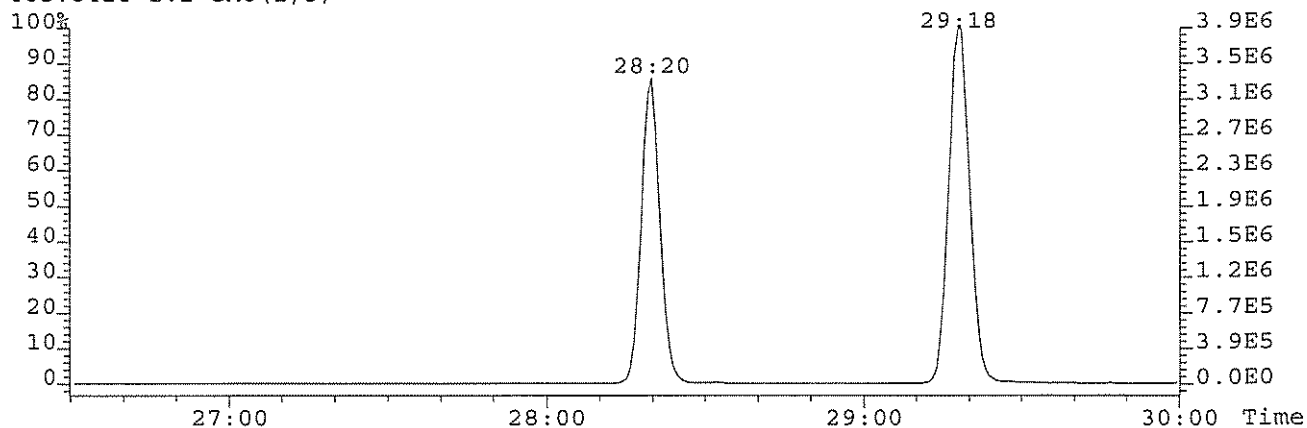
393.8025 S:2 SMO(1,3)



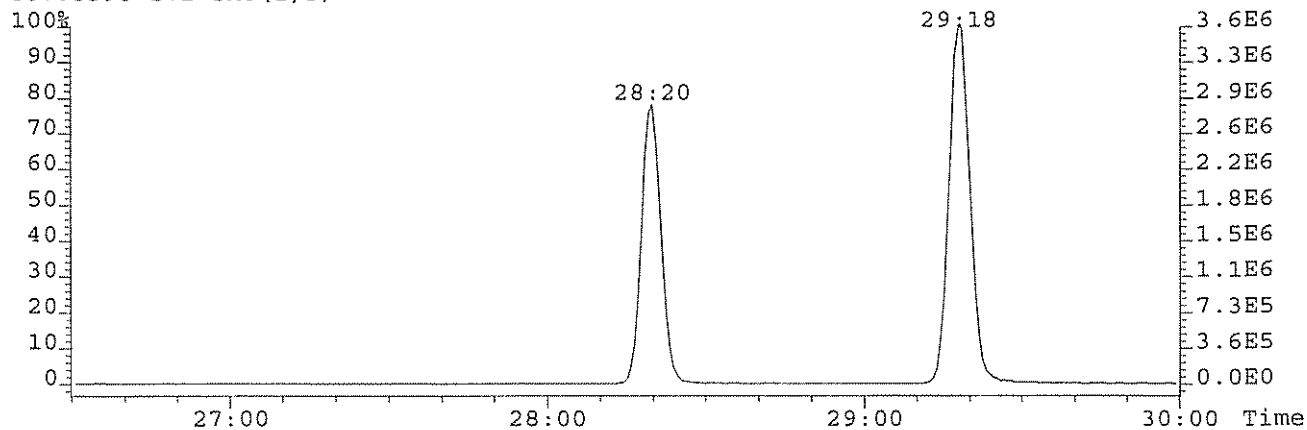
395.7995 S:2 SMO(1,3)



405.8428 S:2 SMO(1,3)



407.8398 S:2 SMO(1,3)

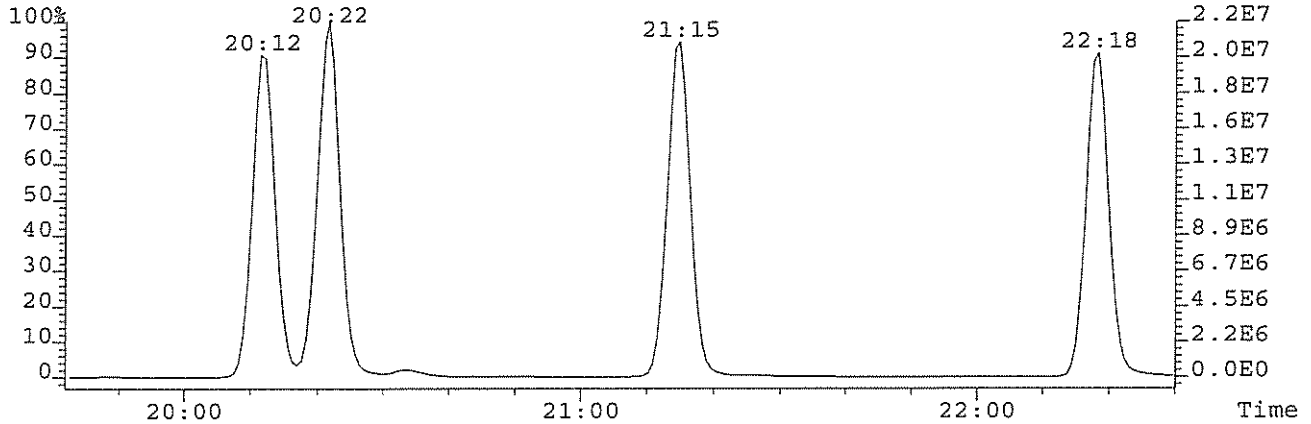


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

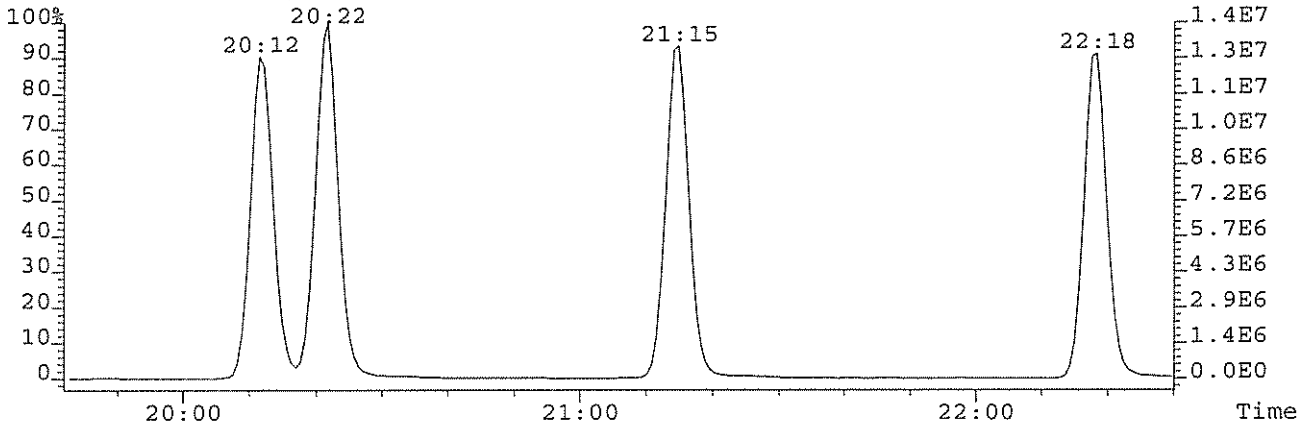
標準物質	
測定日	平成25年7月13日
測定物質	Mono-ortho PCB

File:130713 #1-2898 Acq:13-JUL-2013 12:24:57 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:DFP-STD3 Exp:RH-MP11

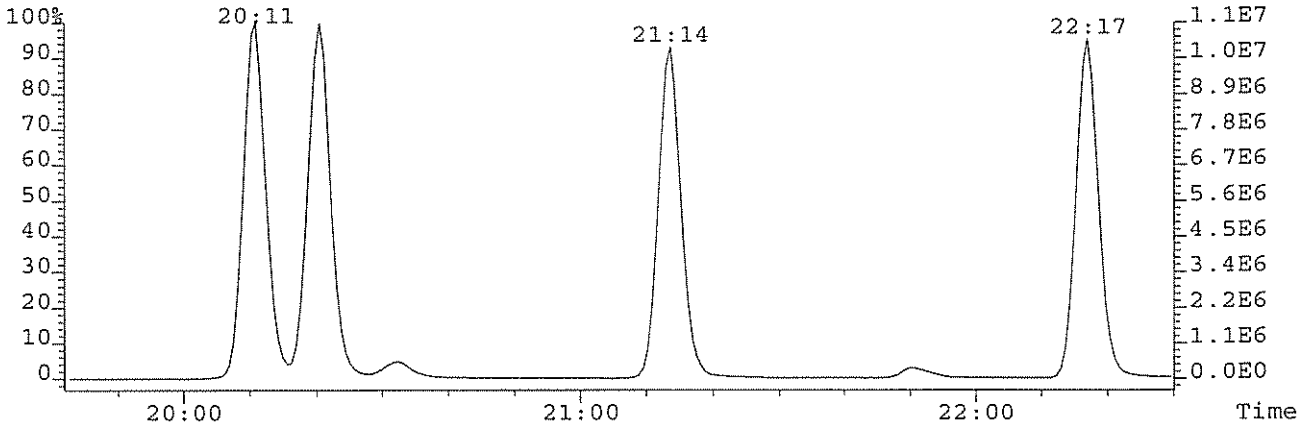
325.8804 S:2 SMO(1,3)



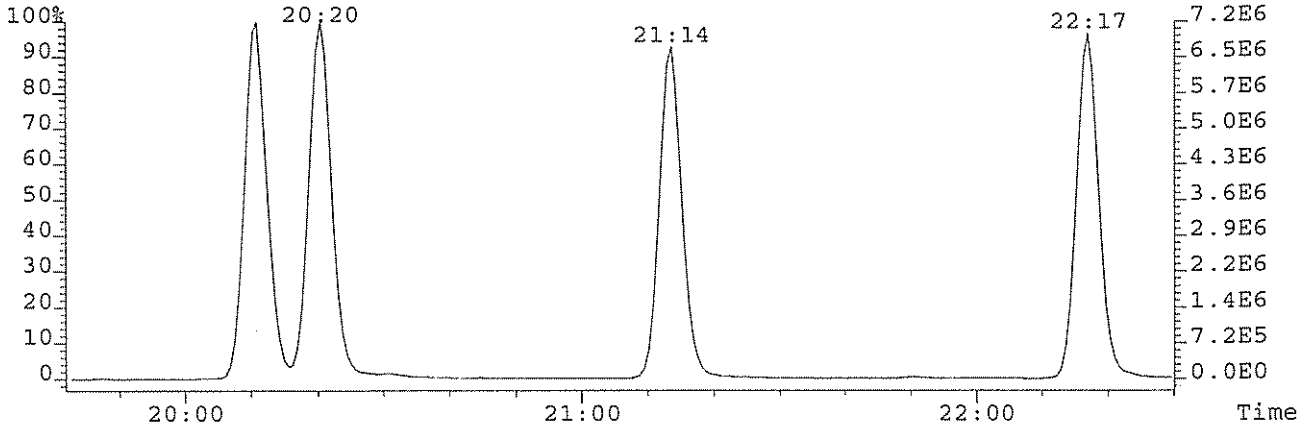
327.8775 S:2 SMO(1,3)



337.9207 S:2 SMO(1,3)



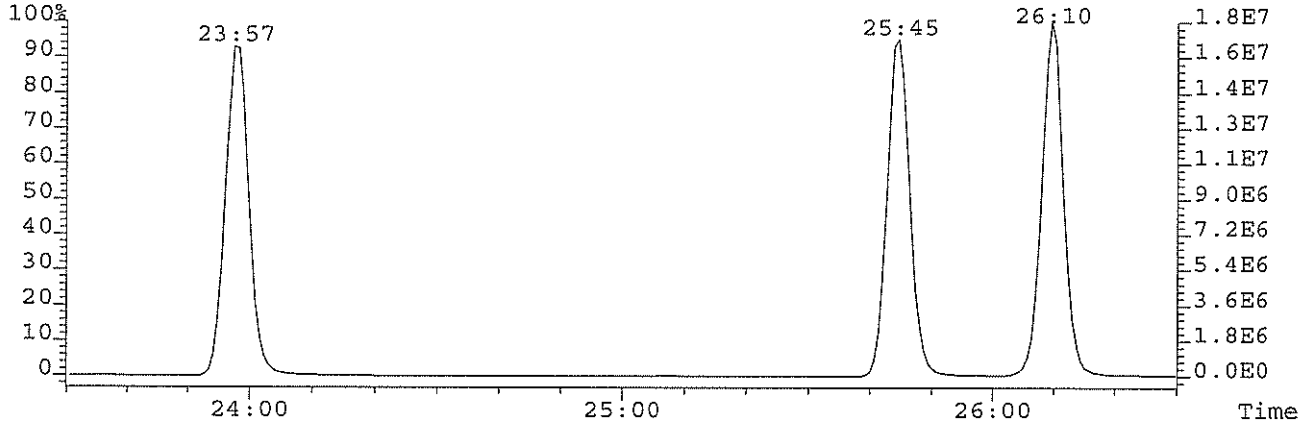
339.9178 S:2 SMO(1,3)



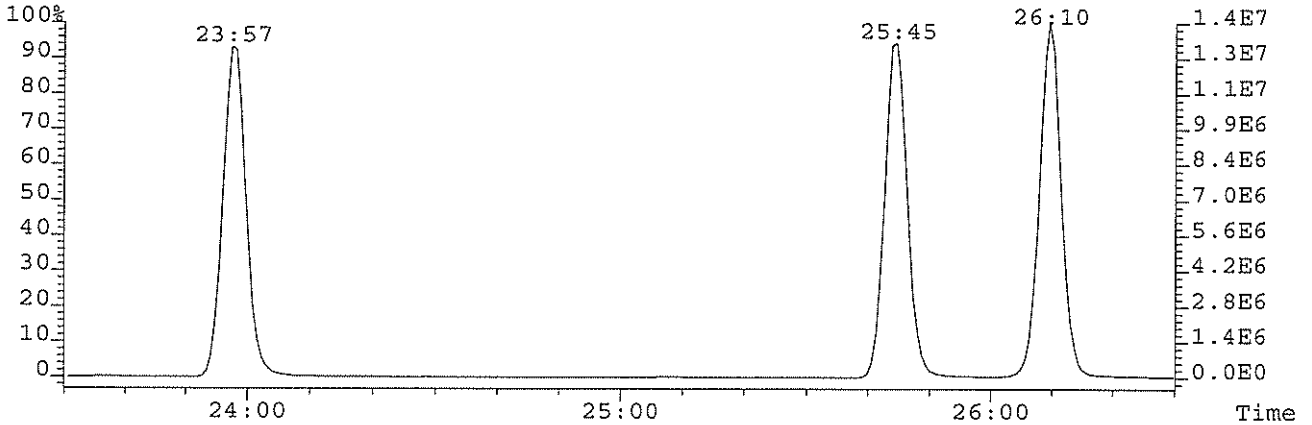
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130713 #1-2898 Acq:13-JUL-2013 12:24:57 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:DFP-STD3 Exp:RH-MP11

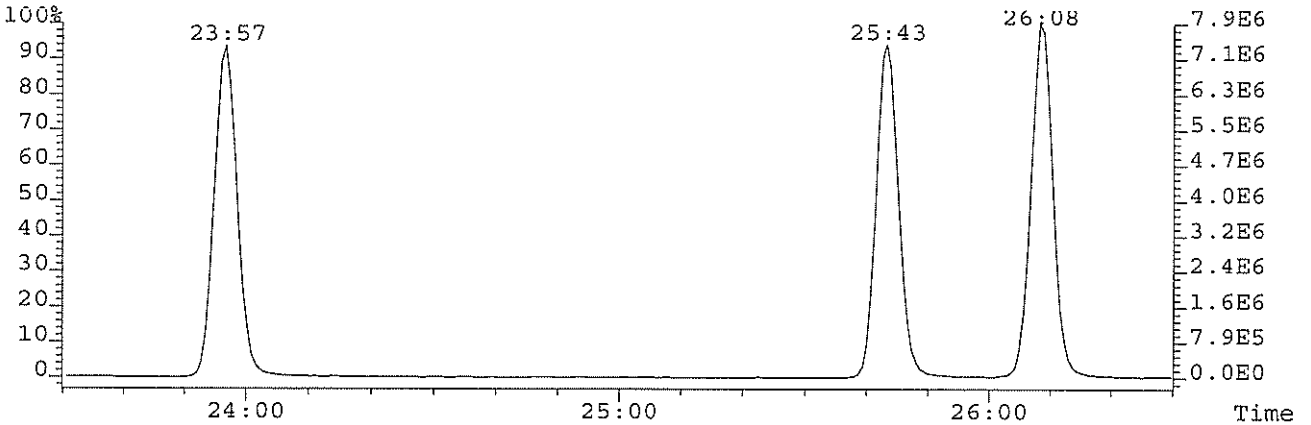
359.8415 S:2 SMO(1,3)



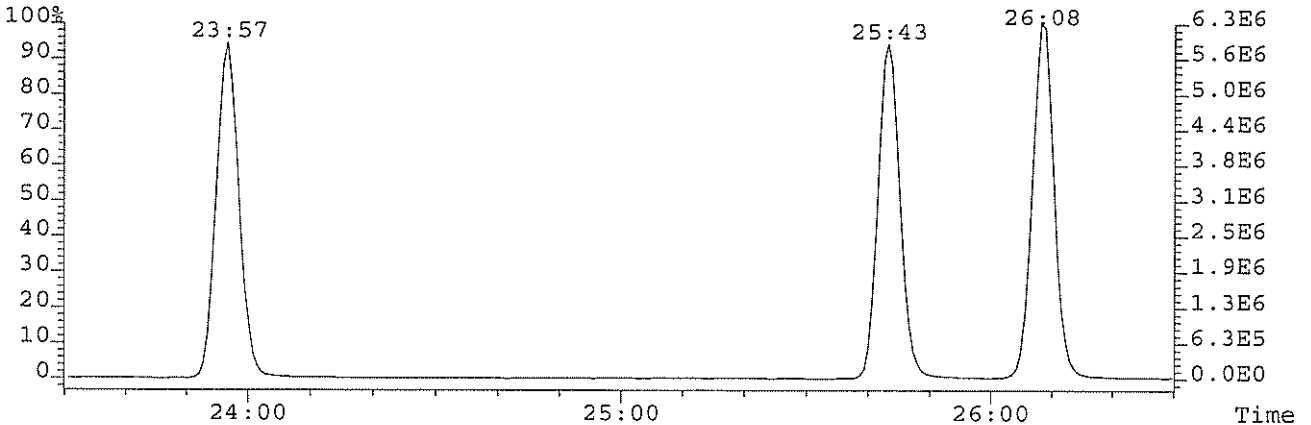
361.8385 S:2 SMO(1,3)



371.8817 S:2 SMO(1,3)



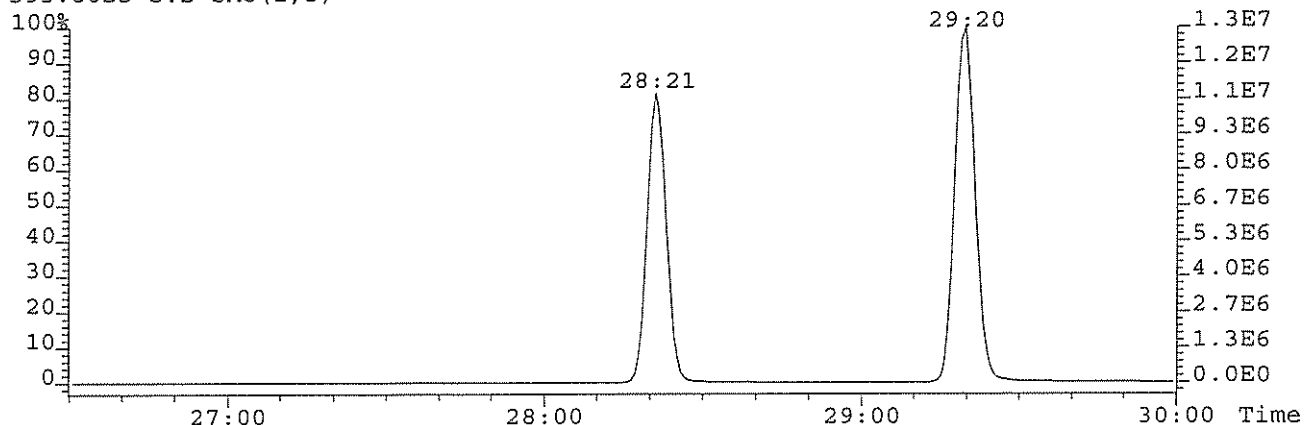
373.8788 S:2 SMO(1,3)



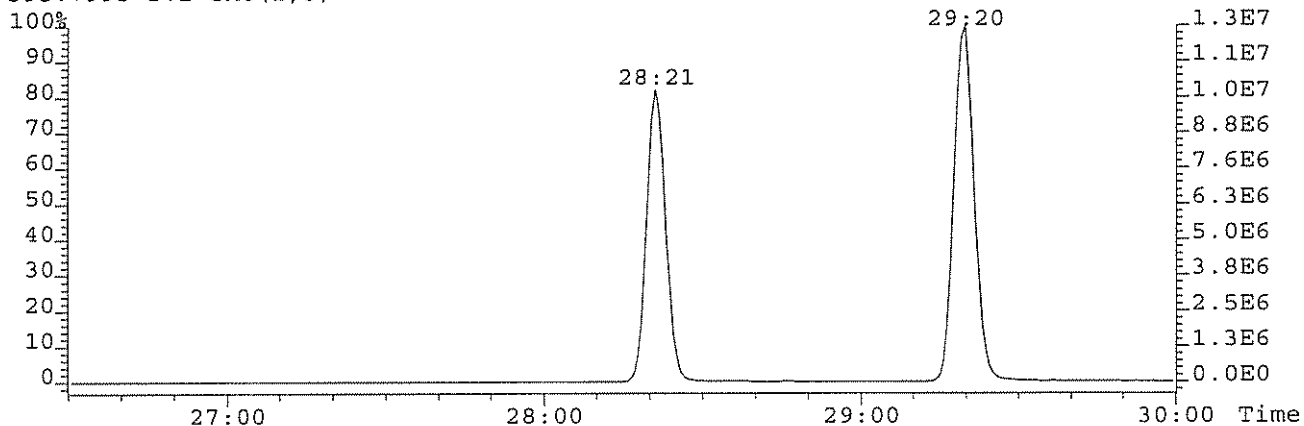
DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130713 #1-2898 Acq:13-JUL-2013 12:24:57 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:DFP-STD3 Exp:RH-MP11

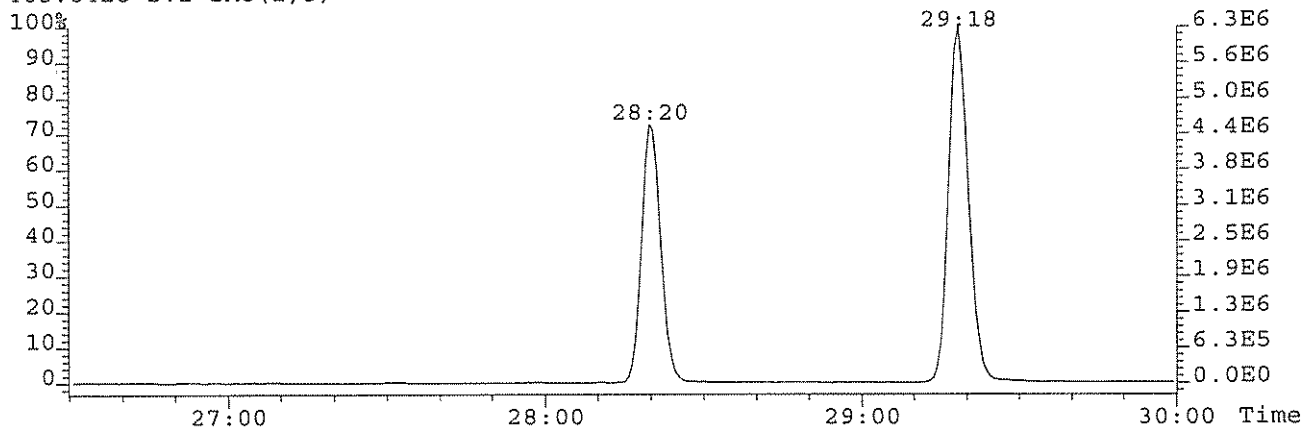
393.8025 S:2 SMO(1,3)



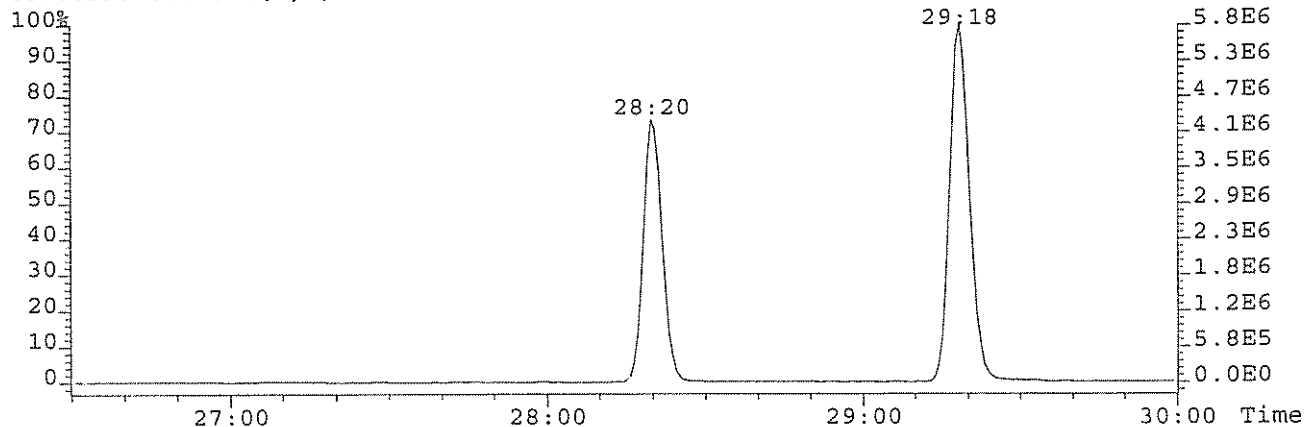
395.7995 S:2 SMO(1,3)



405.8428 S:2 SMO(1,3)



407.8398 S:2 SMO(1,3)

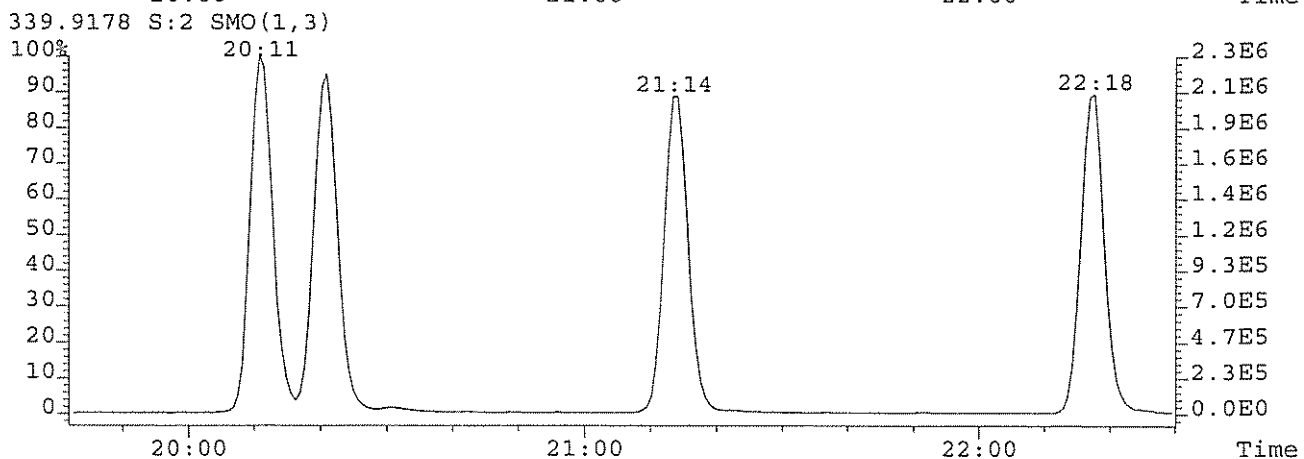
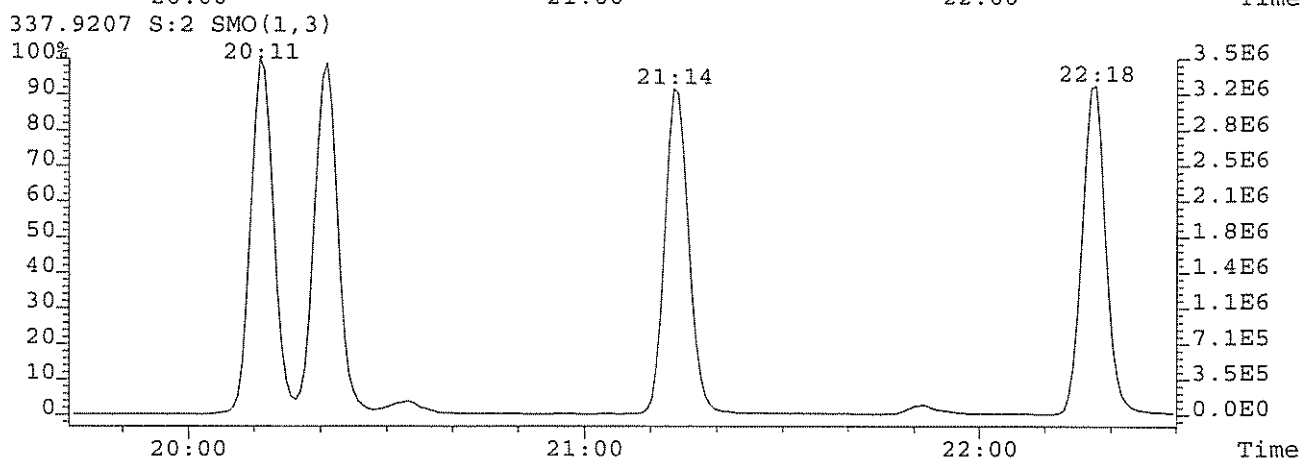
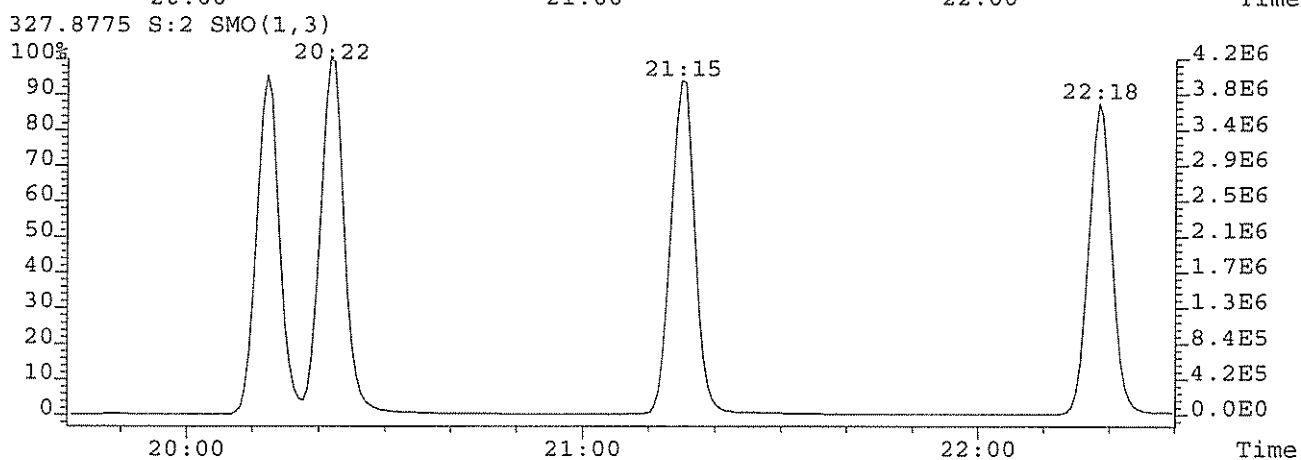
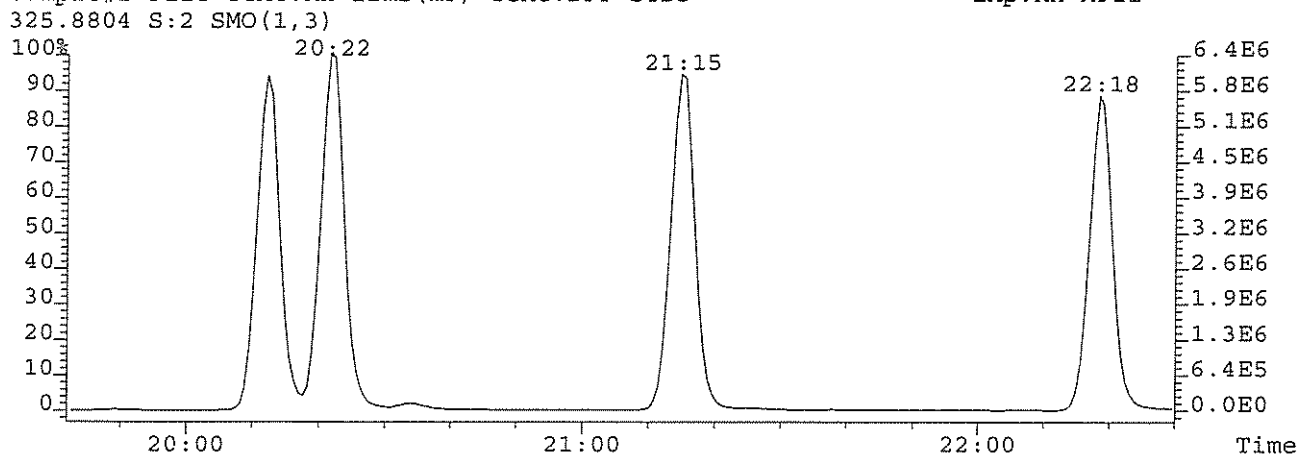


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)



標準物質	
測定日	平成25年7月16日
測定物質	Mono-ortho PCB

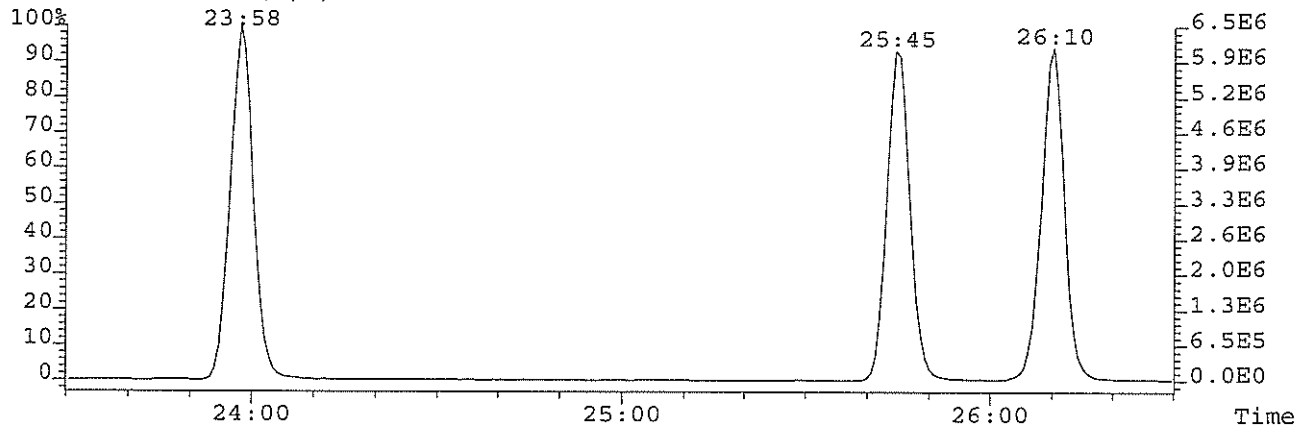
File:130716 #1-2897 Acq:16-JUL-2013 11:22:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:DFP-STD3 Exp:RH-MP11



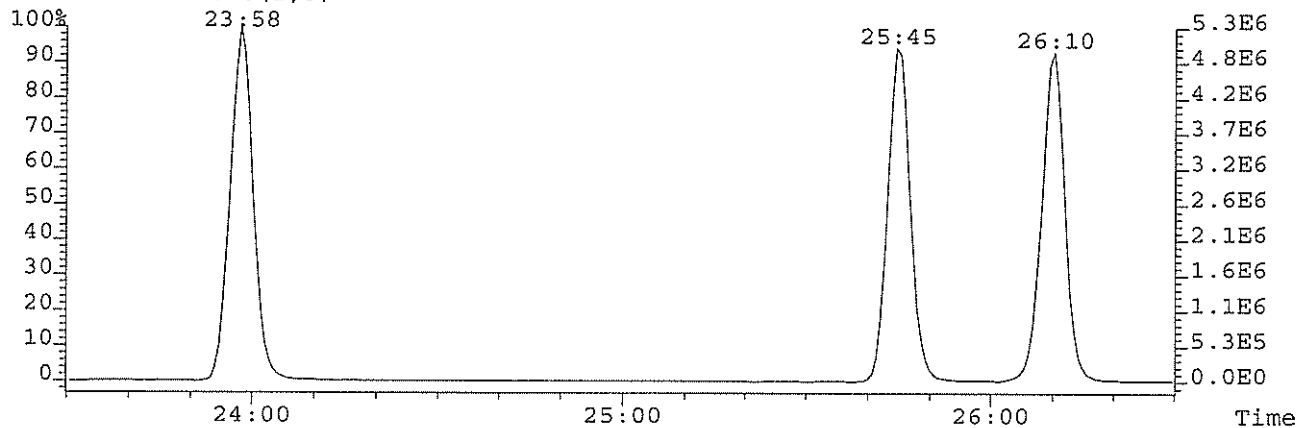
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130716 #1-2897 Acq:16-JUL-2013 11:22:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:DFP-STD3 Exp:RH-MP11

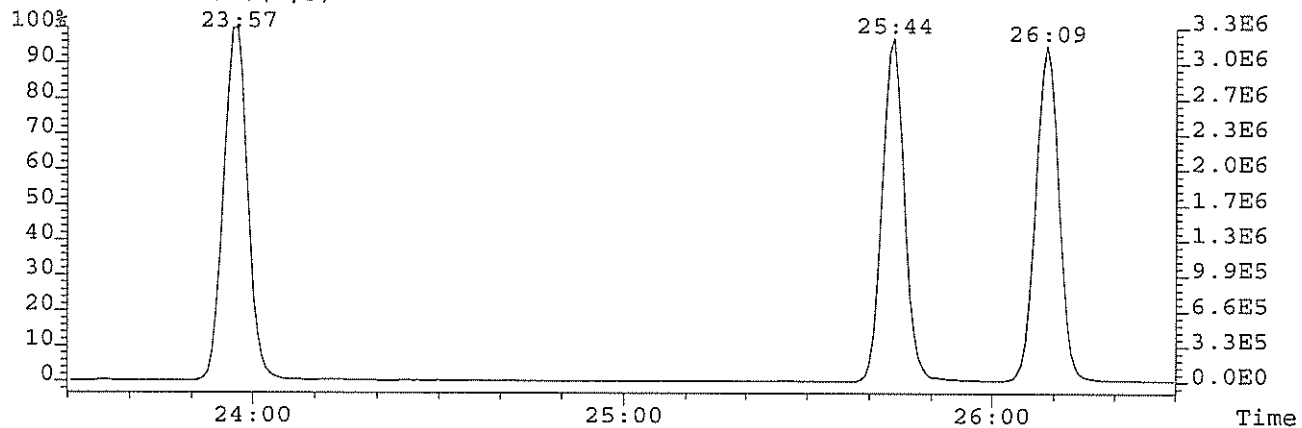
359.8415 S:2 SMO(1,3)



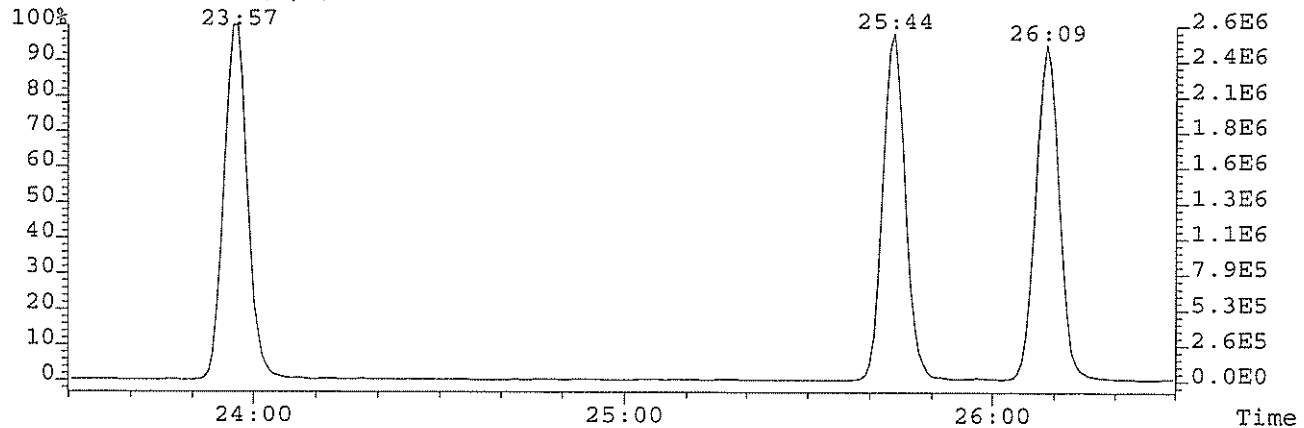
361.8385 S:2 SMO(1,3)



371.8817 S:2 SMO(1,3)



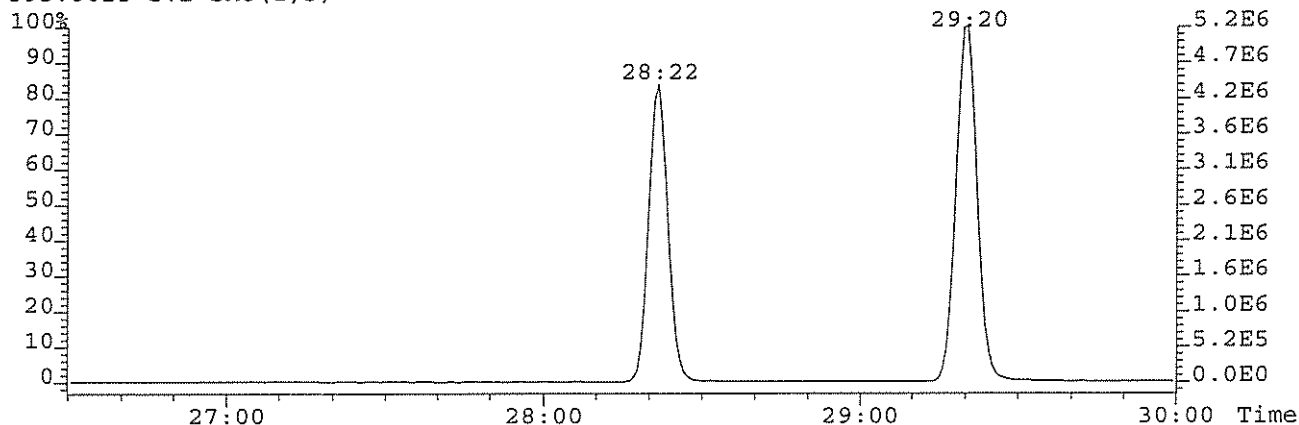
373.8788 S:2 SMO(1,3)



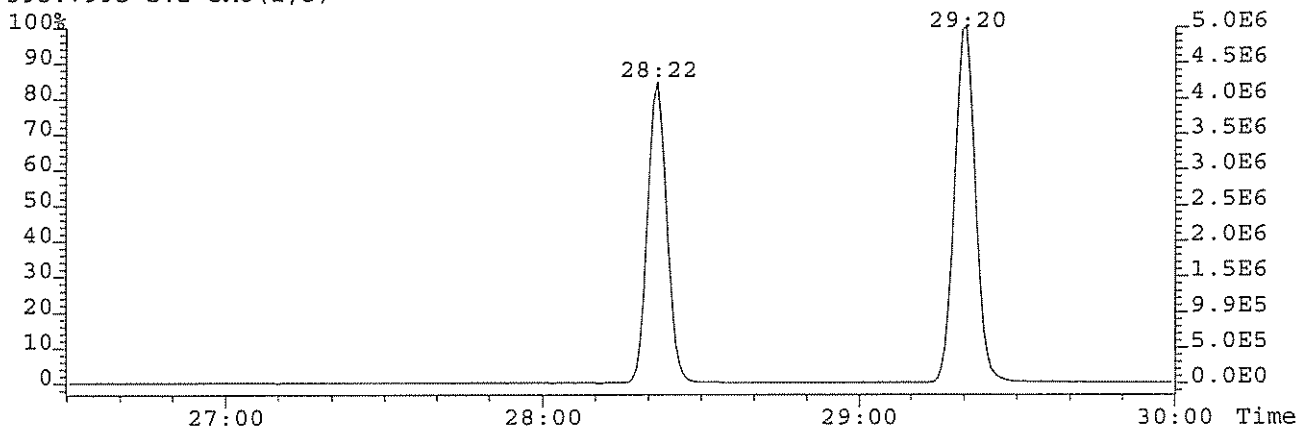
DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130716 #1-2897 Acq:16-JUL-2013 11:22:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:DFP-STD3 Exp:RH-MP11

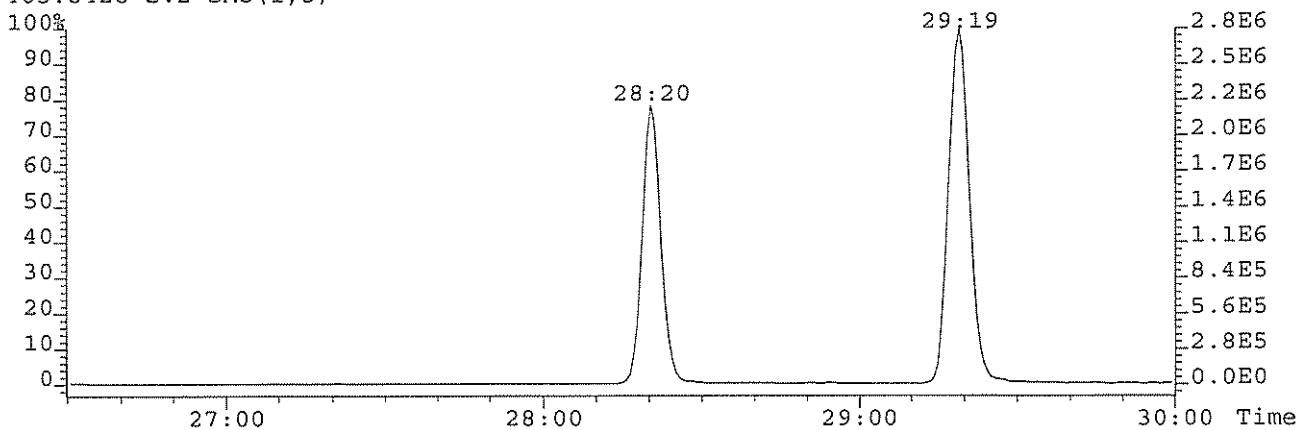
393.8025 S:2 SMO(1,3)



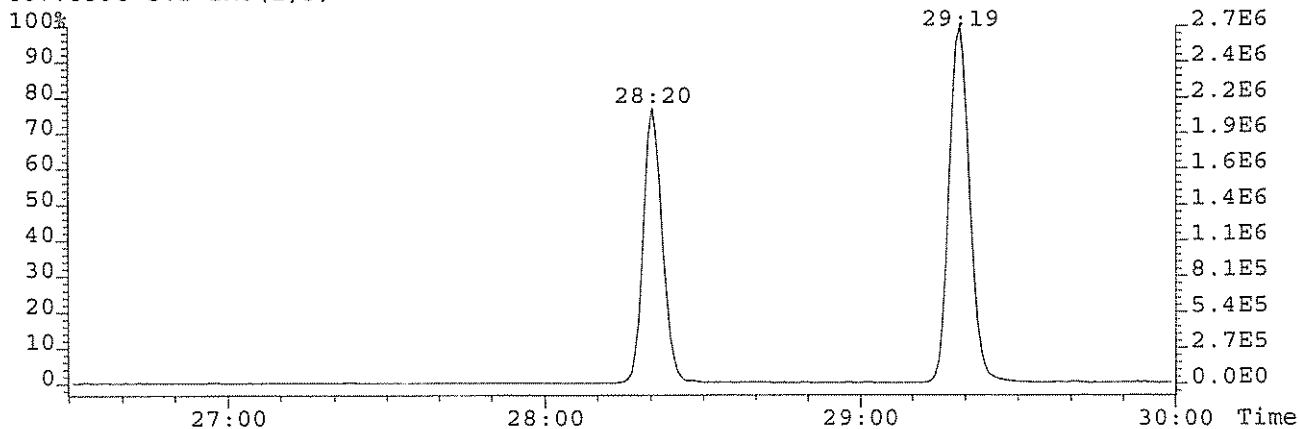
395.7995 S:2 SMO(1,3)



405.8428 S:2 SMO(1,3)



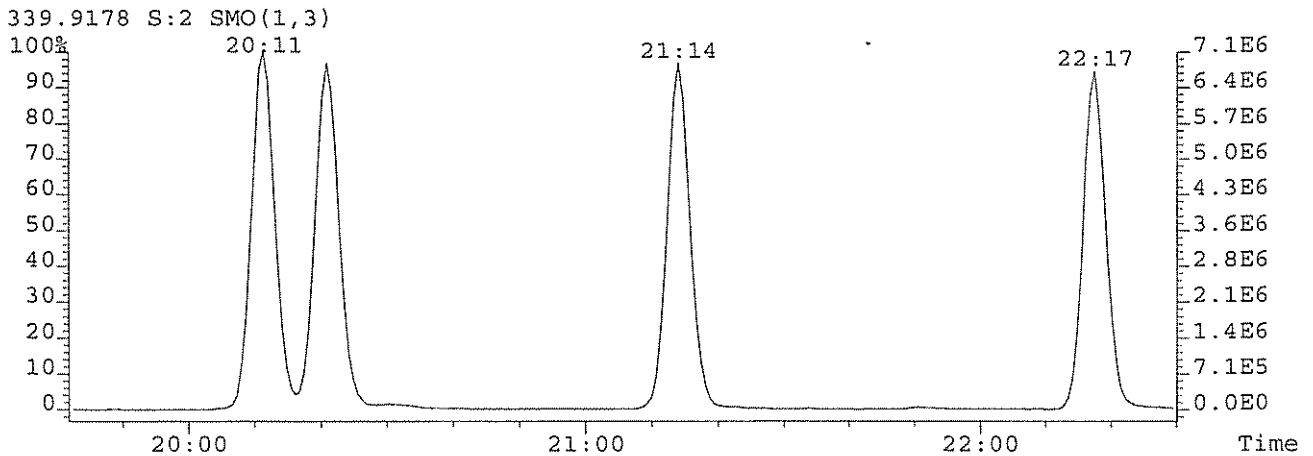
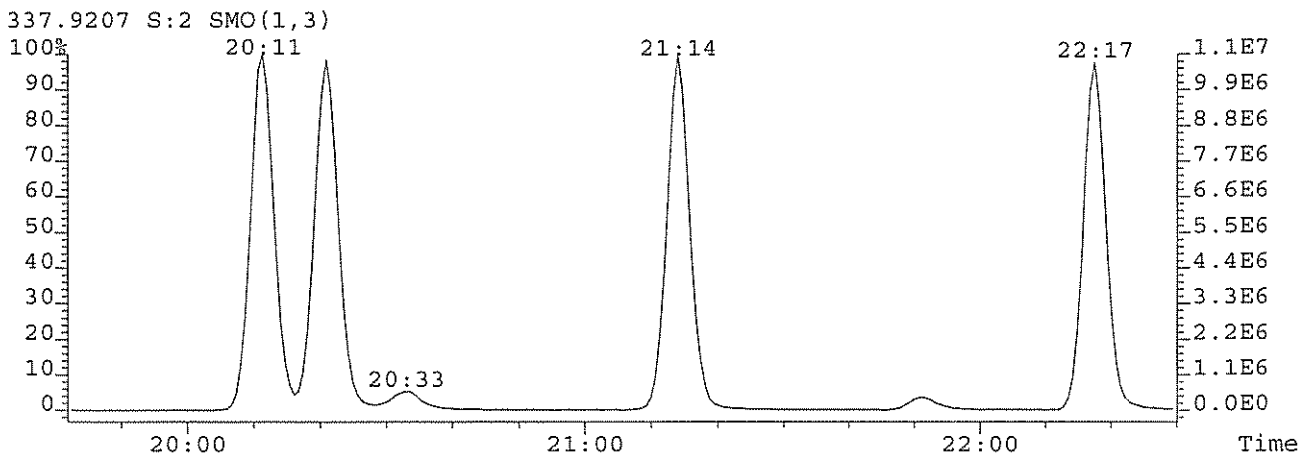
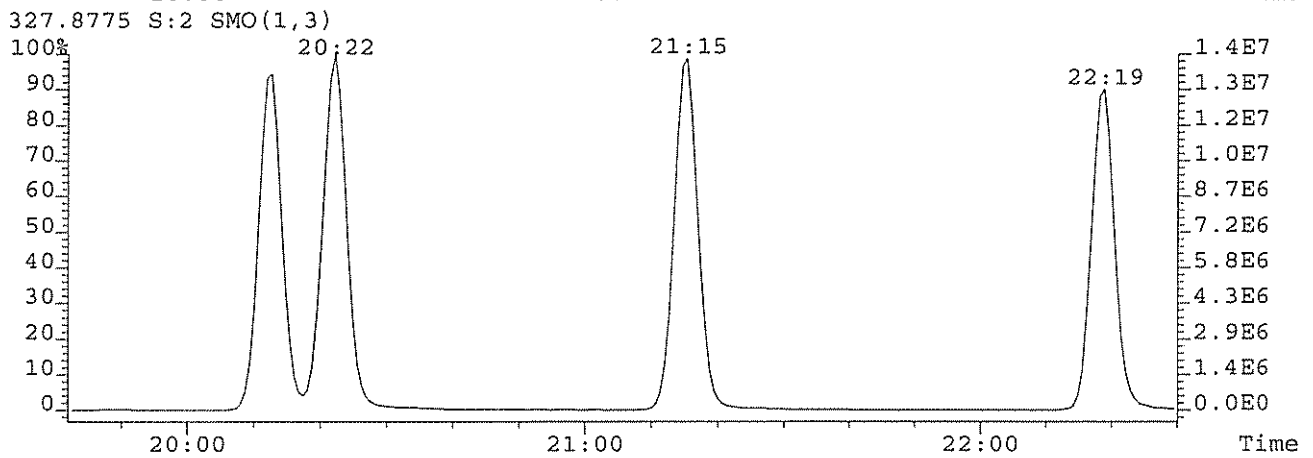
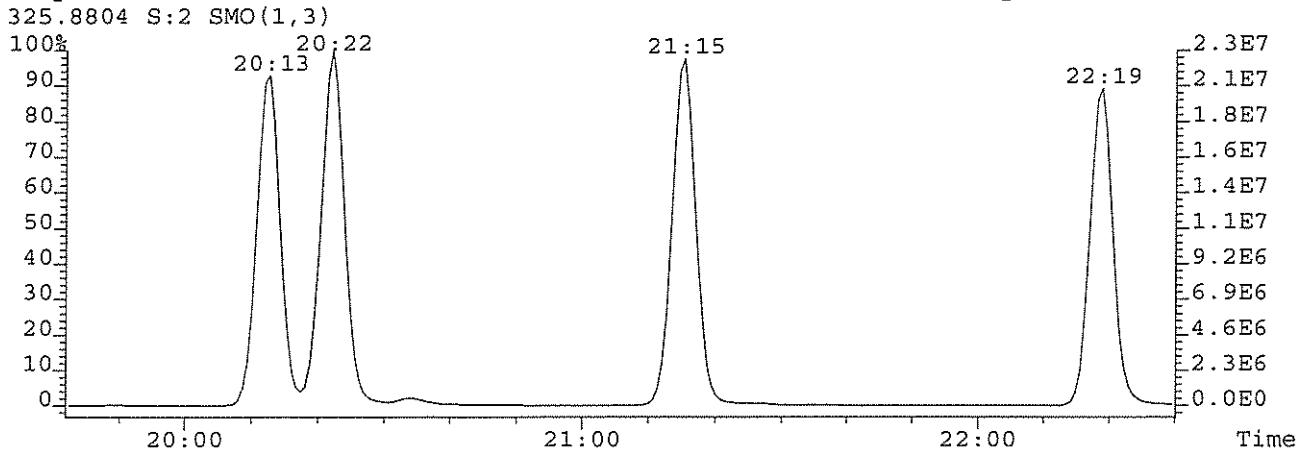
407.8398 S:2 SMO(1,3)



DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

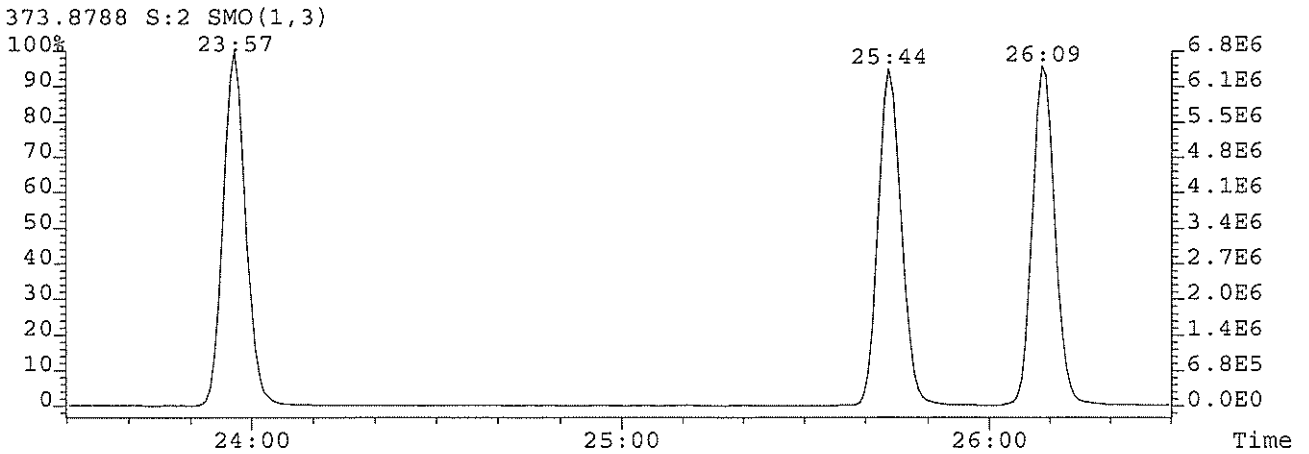
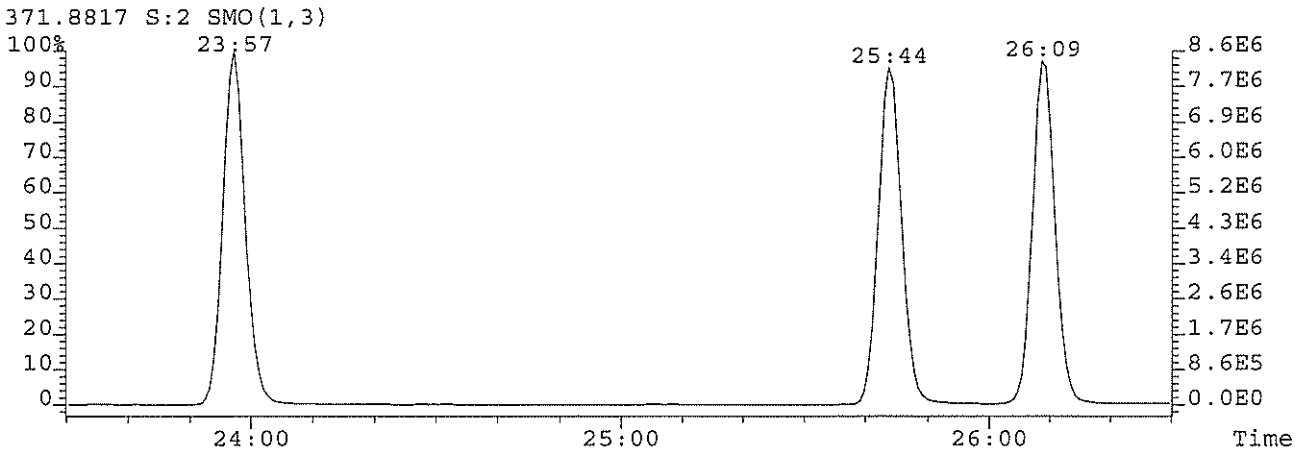
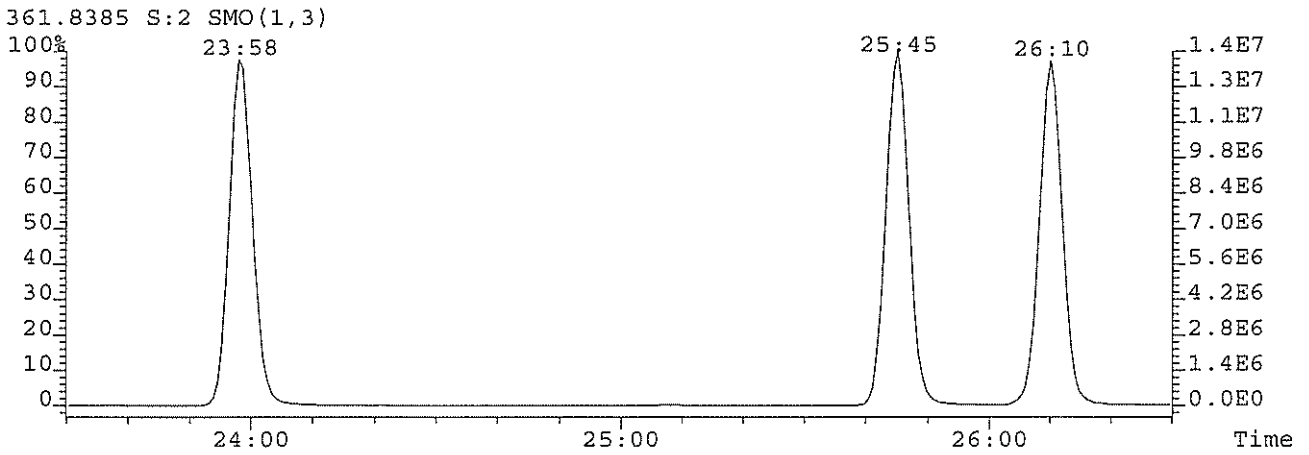
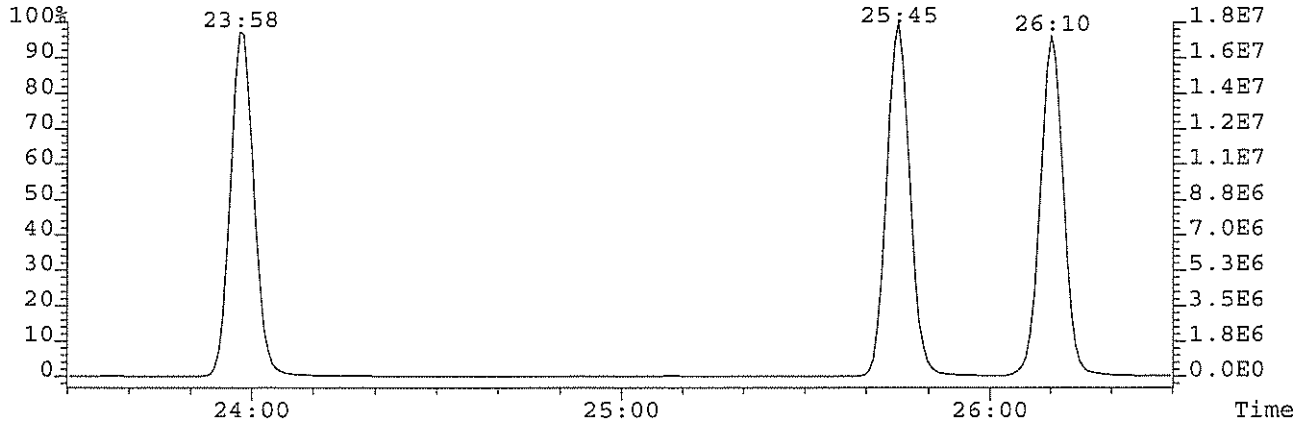
標準物質	
測定日	平成25年7月17日
測定物質	Mono-ortho PCB

File:130717 #1-2898 Acq:17-JUL-2013 10:32:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:DFP-STD3 Exp:RH-MP11



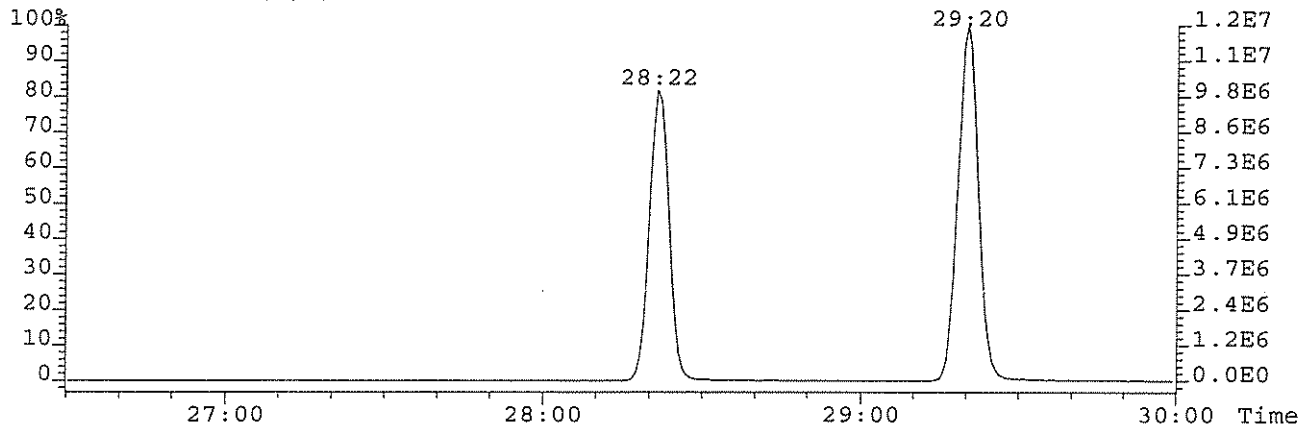
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130717 #1-2898 Acq:17-JUL-2013 10:32:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:DFP-STD3 Exp:RH-MP11  
359.8415 S:2 SMO(1,3)

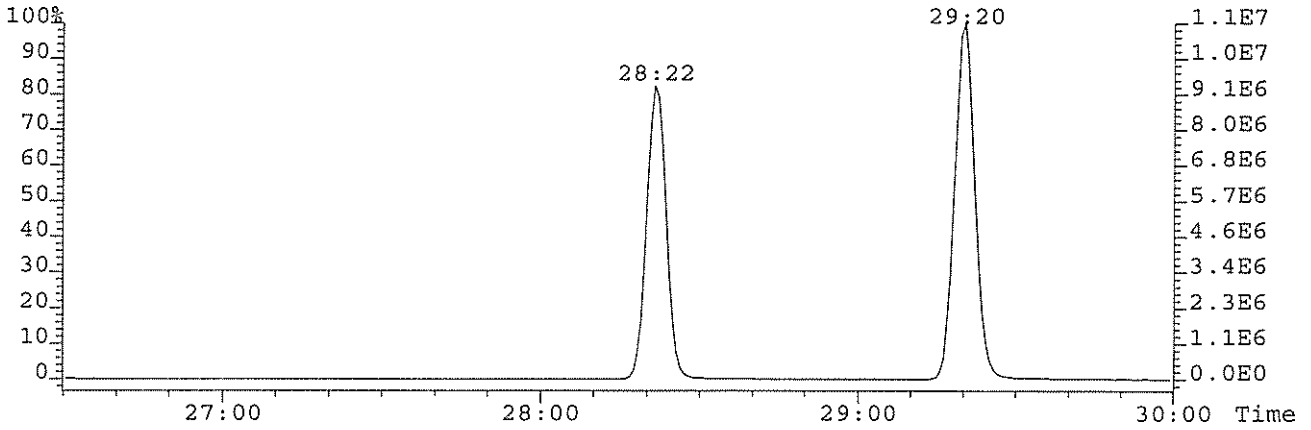


DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

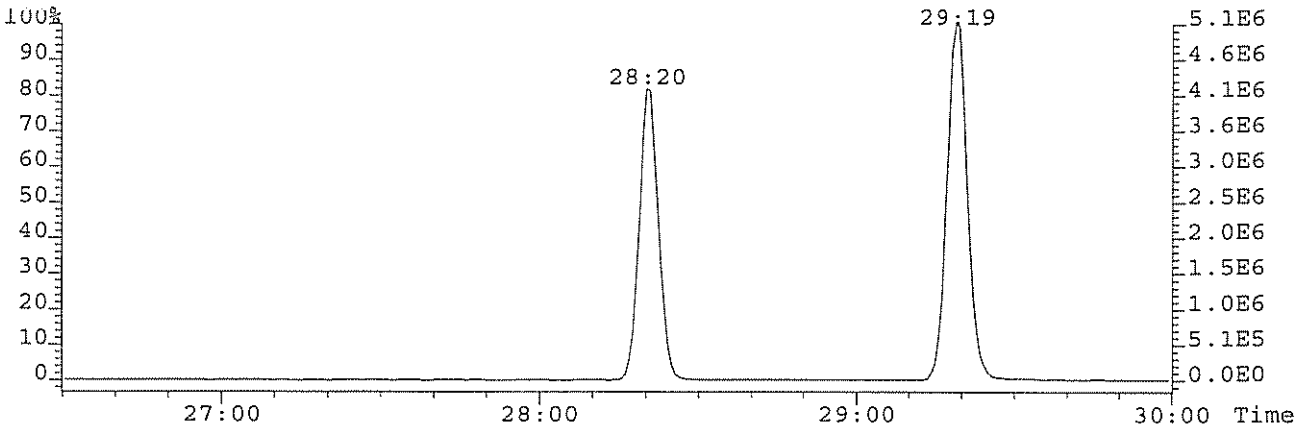
File:130717 #1-2898 Acq:17-JUL-2013 10:32:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:DFP-STD3 Exp:RH-MP11  
393.8025 S:2 SMO(1,3)



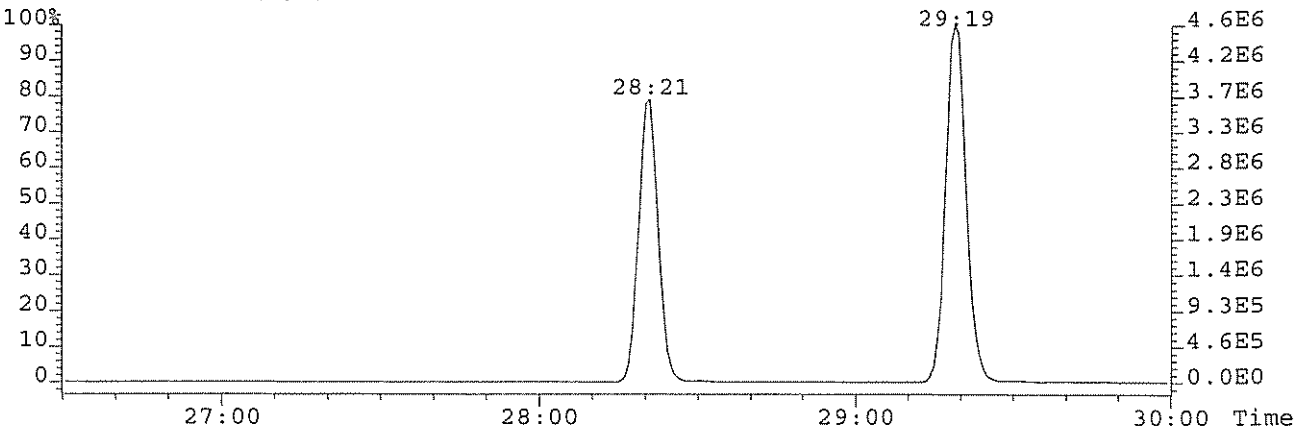
395.7995 S:2 SMO(1,3)



405.8428 S:2 SMO(1,3)



407.8398 S:2 SMO(1,3)

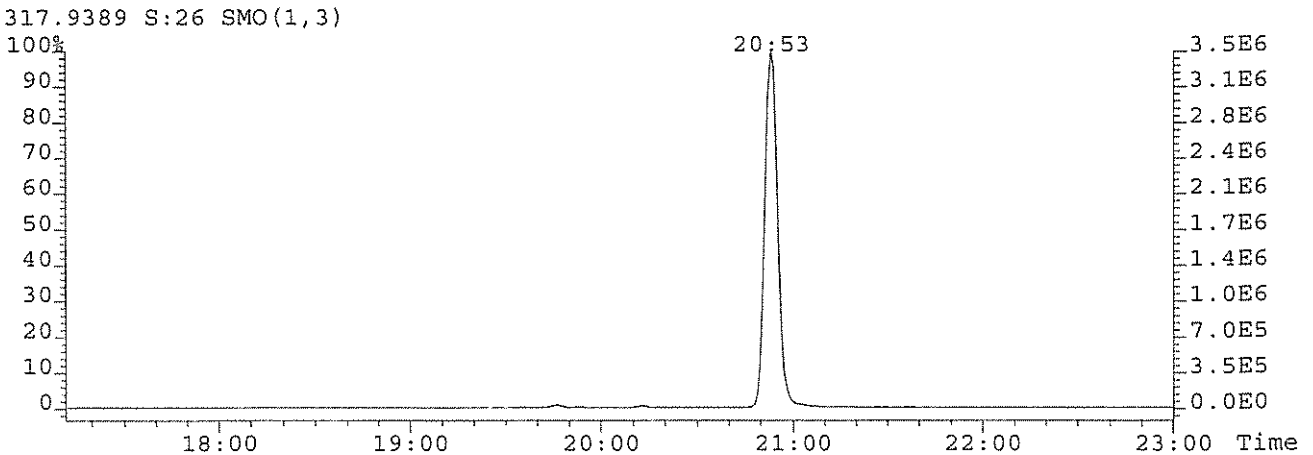
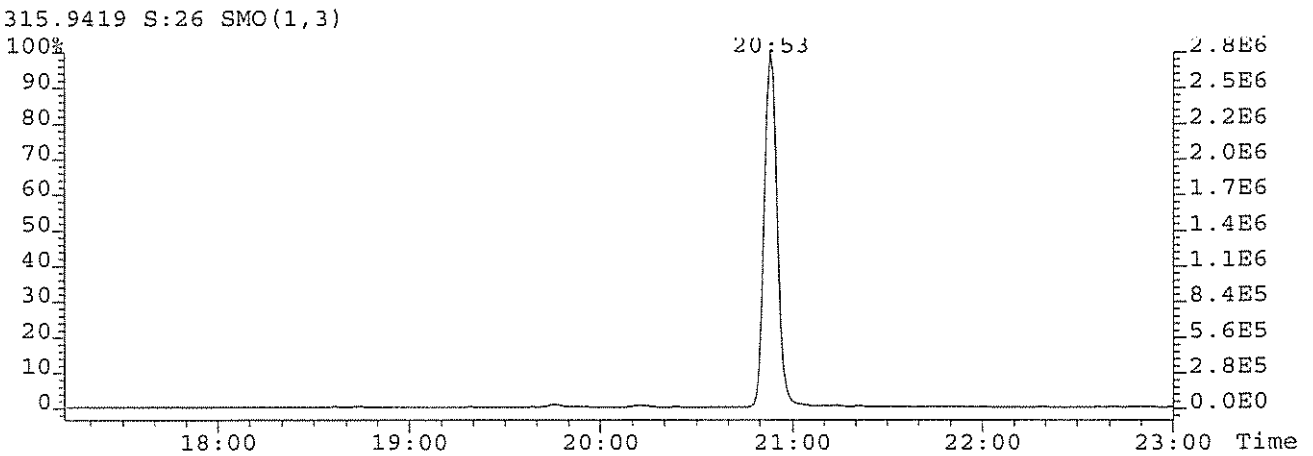
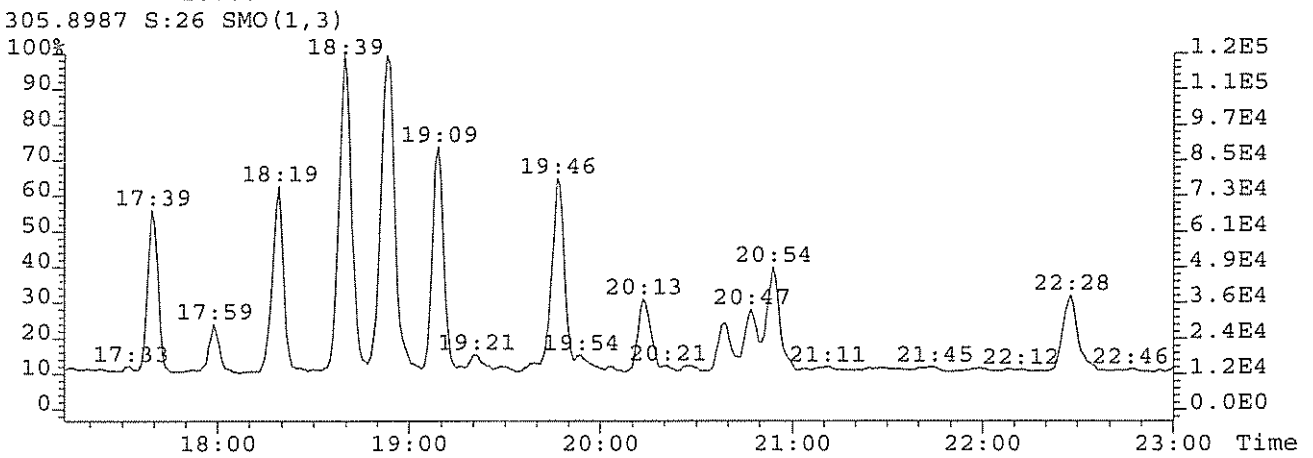
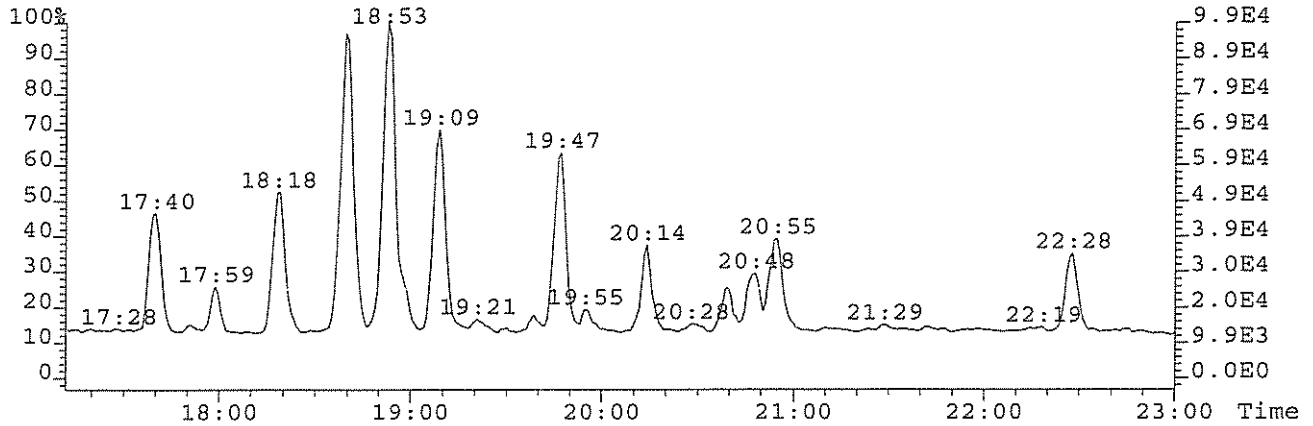


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)



試料管理番号	XE 130945
採取場所	旧嘉手納飛行場
試料名	仮置土

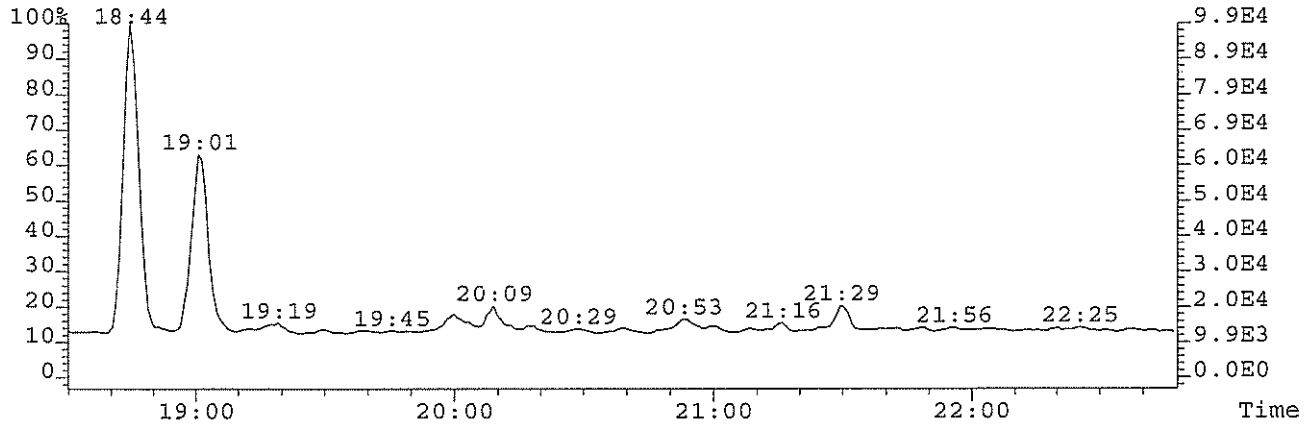
File:130712-2 #1-1578 Acq:13-JUL-2013 11:43:10 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#26 File Text:BPX-DXN(4-6DXN) Text:XE13 0945 Exp:BPX04  
303.9016 S:26 SMO(1,3)



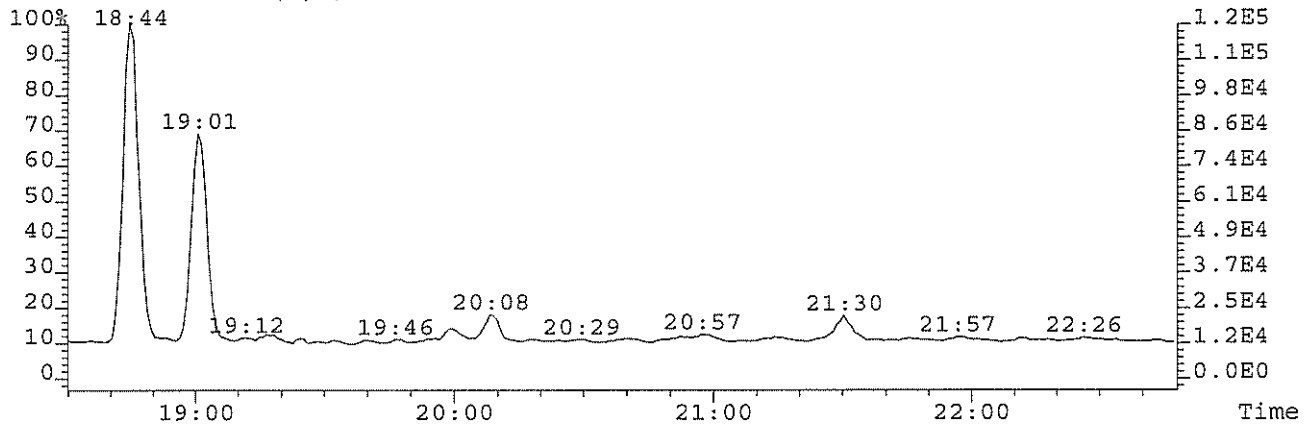
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 11:43:10 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#26 File Text:BPX-DXN(4-6DXN) Text:XE13 0945 Exp:BPX04

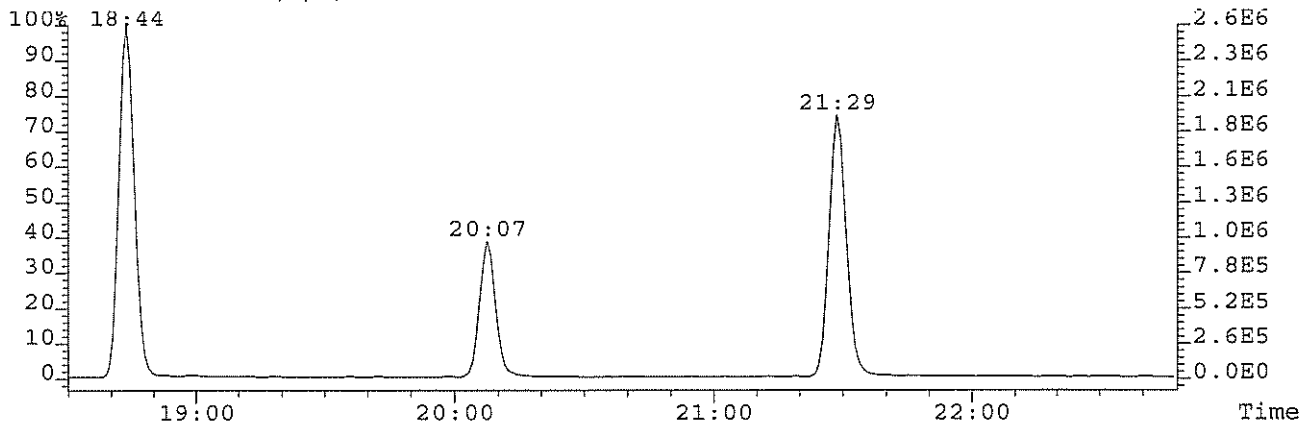
319.8965 S:26 SMO(1,3)



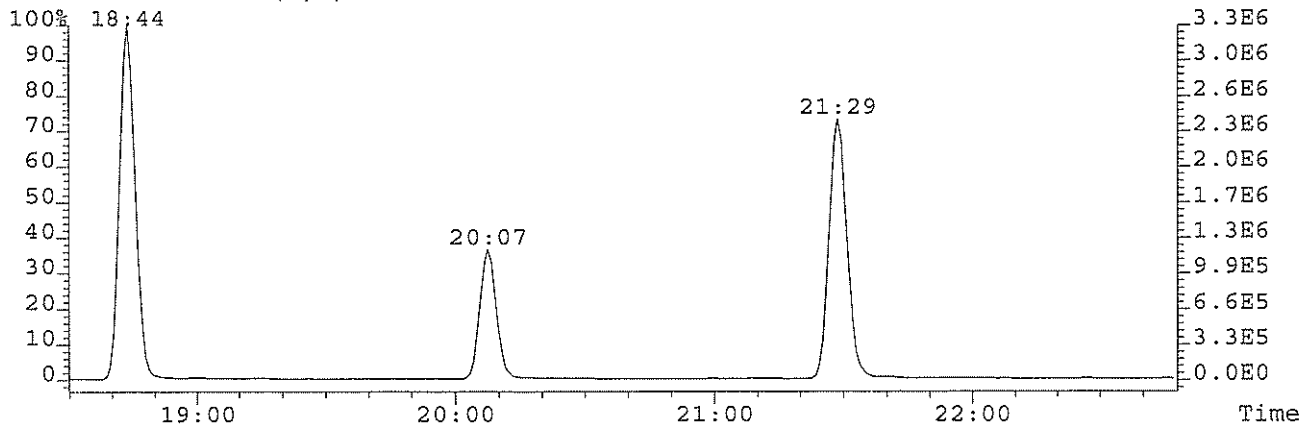
321.8936 S:26 SMO(1,3)



331.9368 S:26 SMO(1,3)

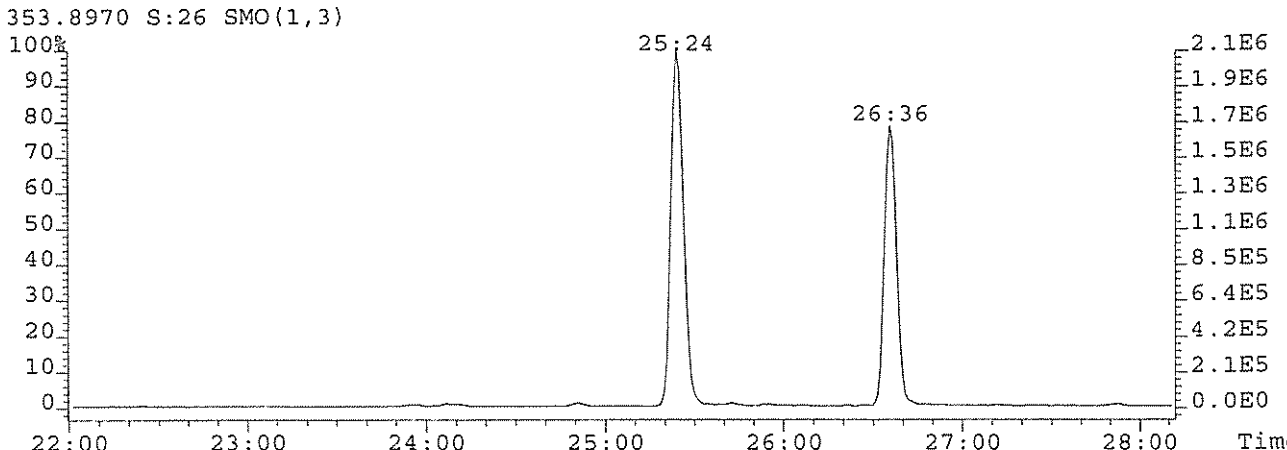
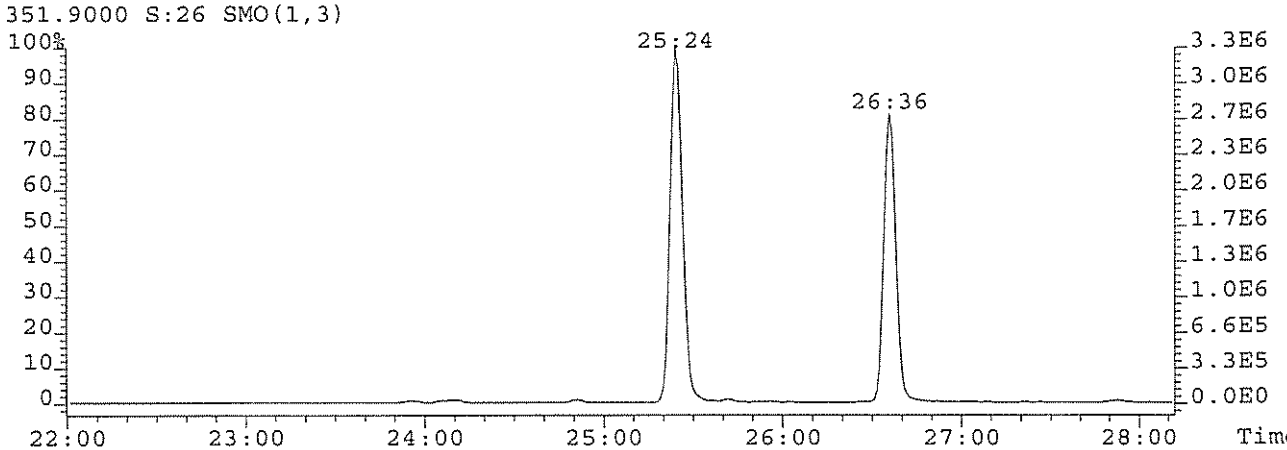
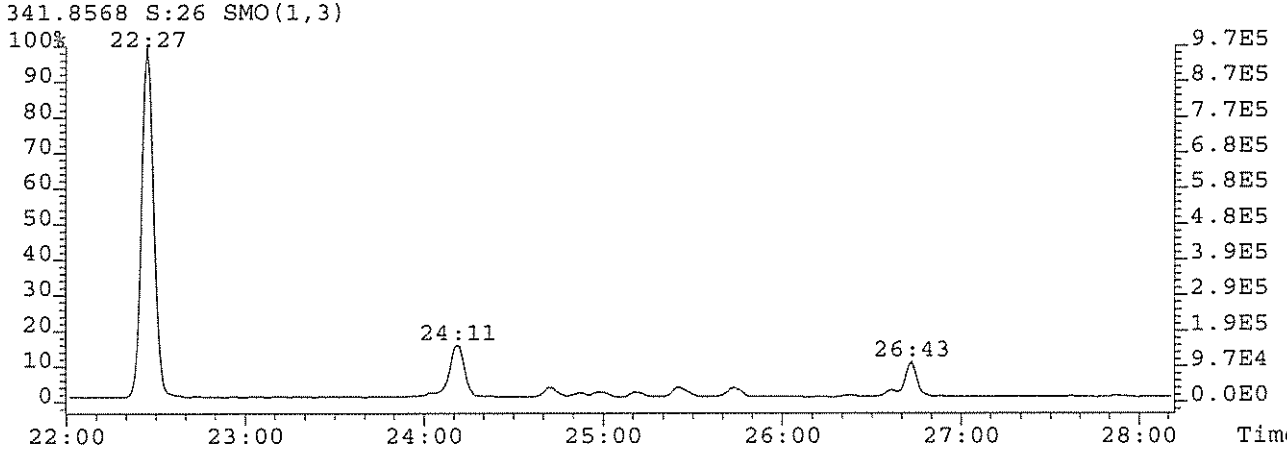
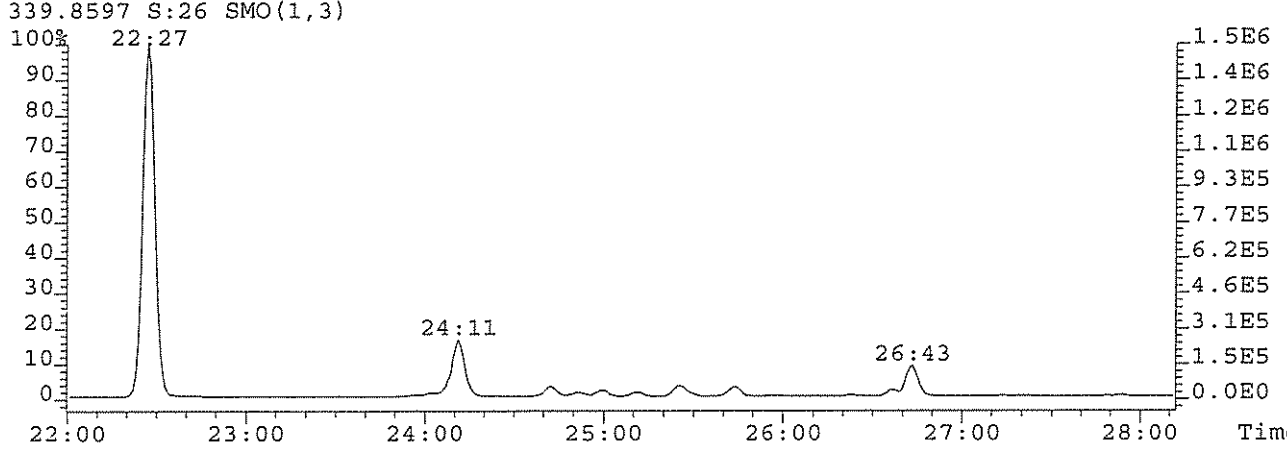


333.9339 S:26 SMO(1,3)



PCDDsクロマトグラム (2)  
(TeCDDs)

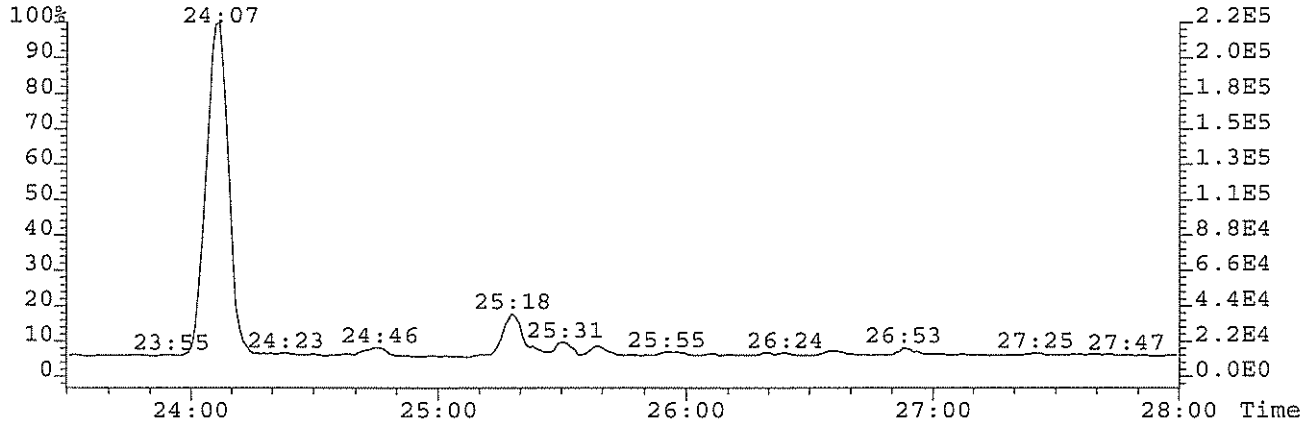
File:130712-2 #1-1578 Acq:13-JUL-2013 11:43:10 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#26 File Text:BPX-DXN(4-6DXN) Text:XE13 0945 Exp:BPX04



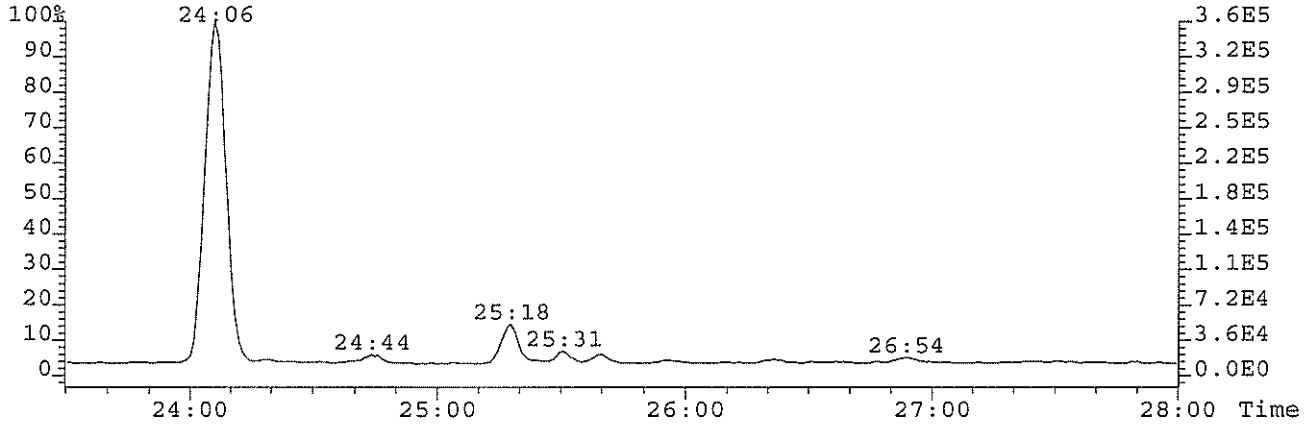
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 11:43:10 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#26 File Text:BPX-DXN(4-6DXN) Text:XE13 0945 Exp:BPX04

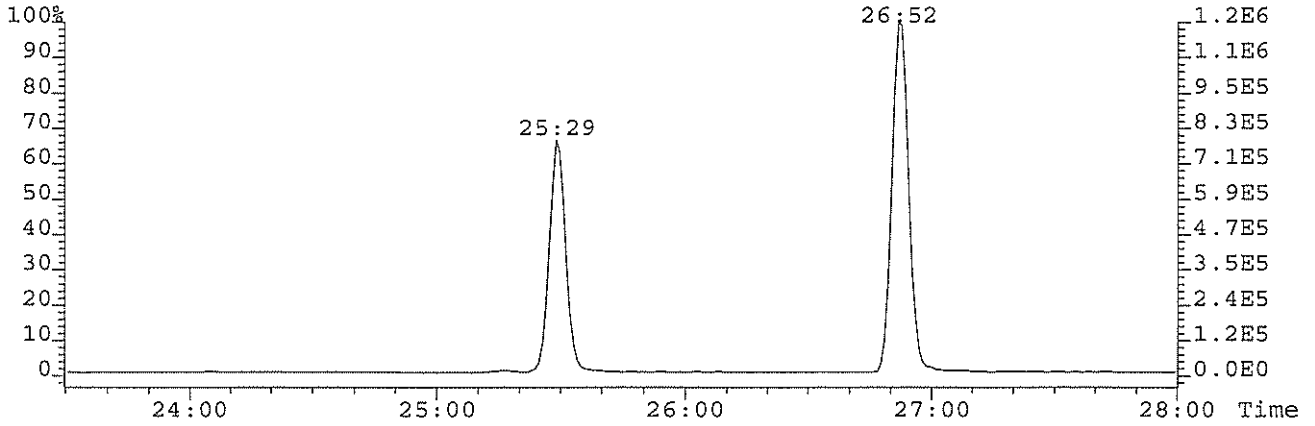
353.8576 S:26 SMO(1,3)



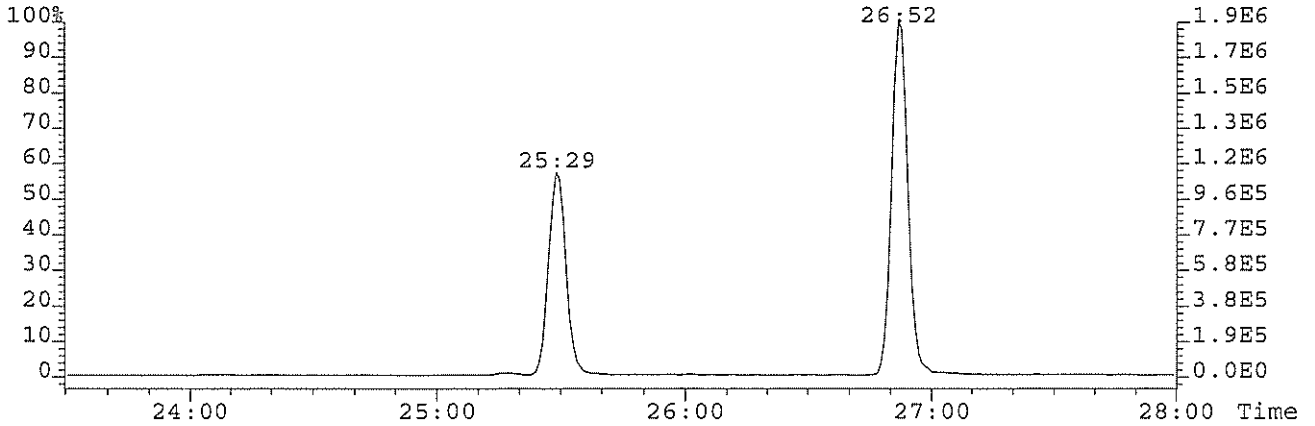
355.8546 S:26 SMO(1,3)



365.8978 S:26 SMO(1,3)

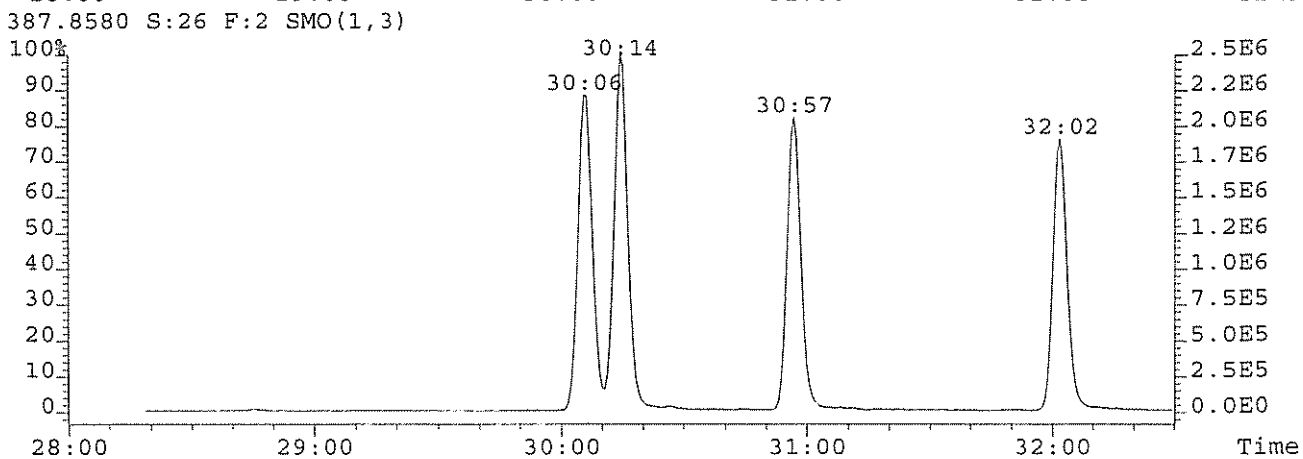
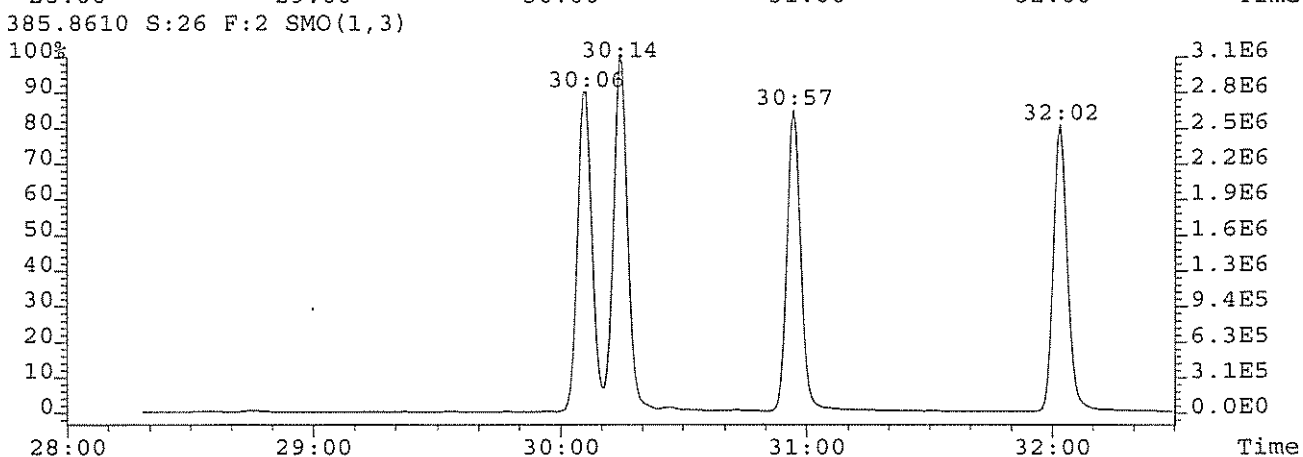
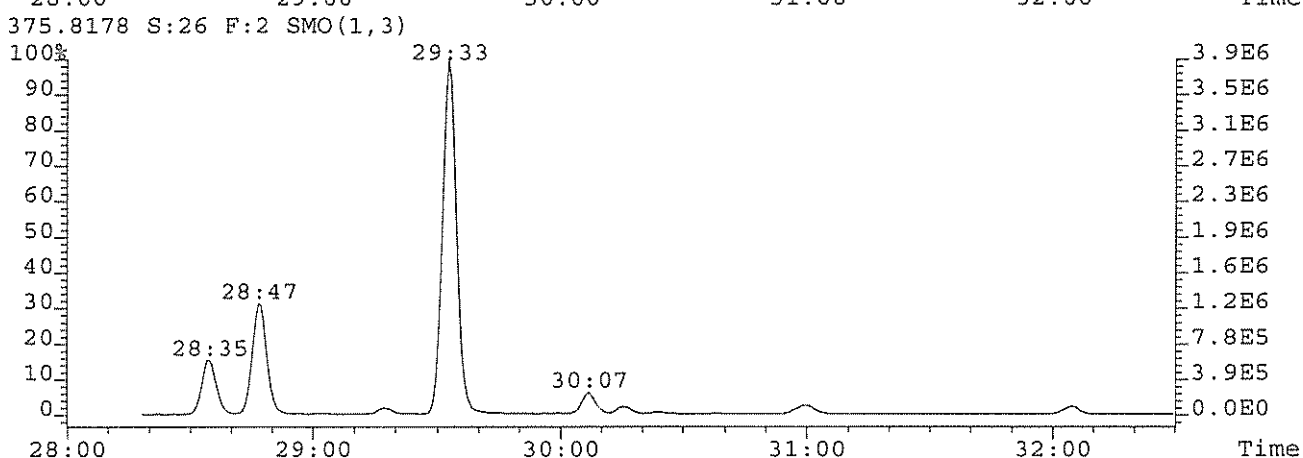
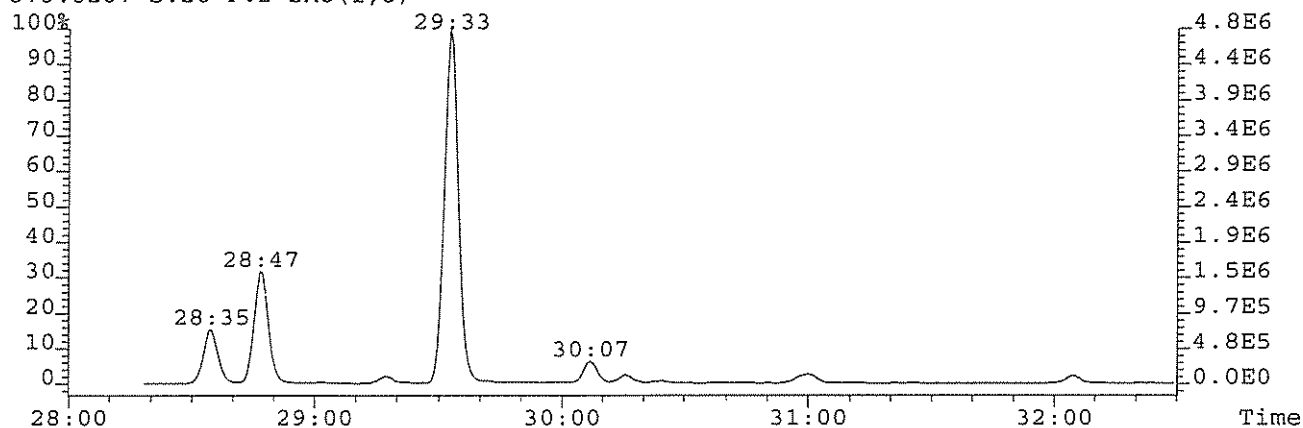


367.8949 S:26 SMO(1,3)



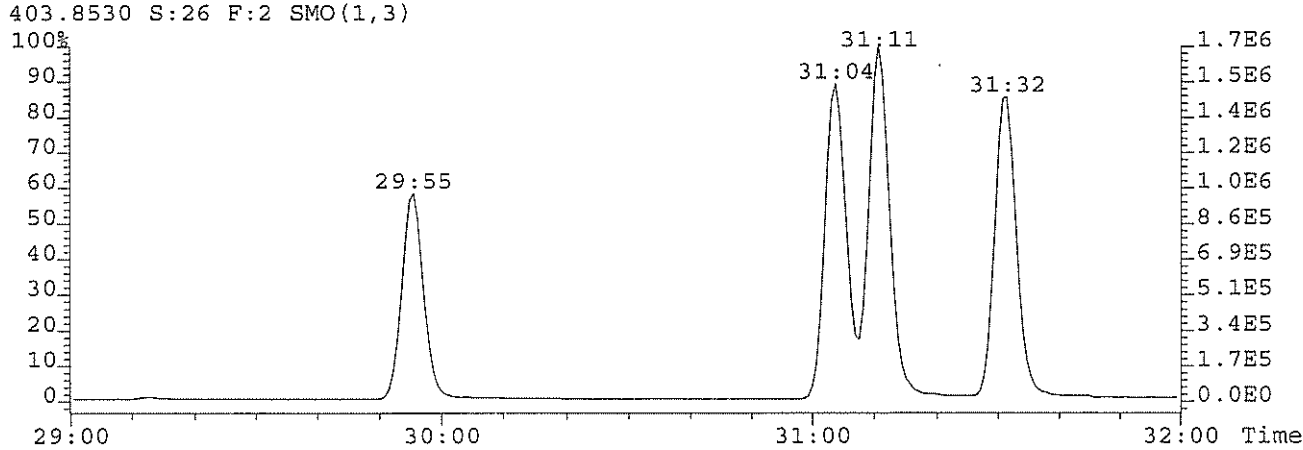
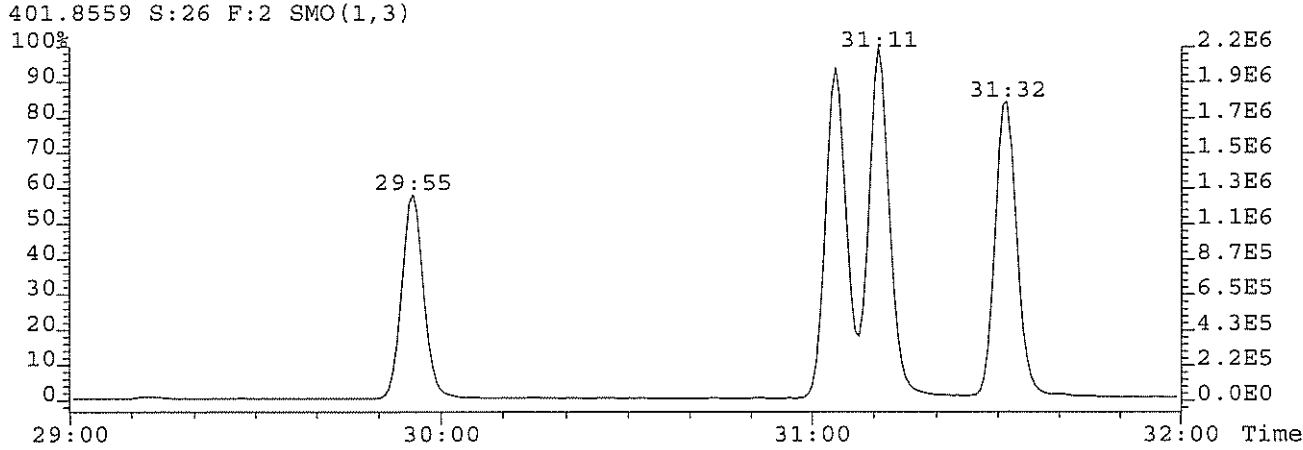
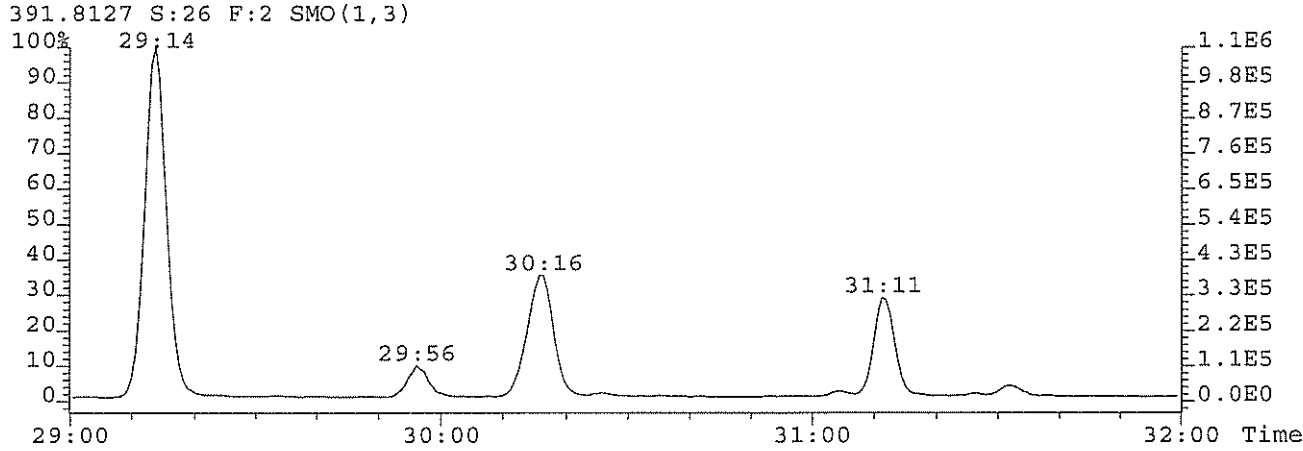
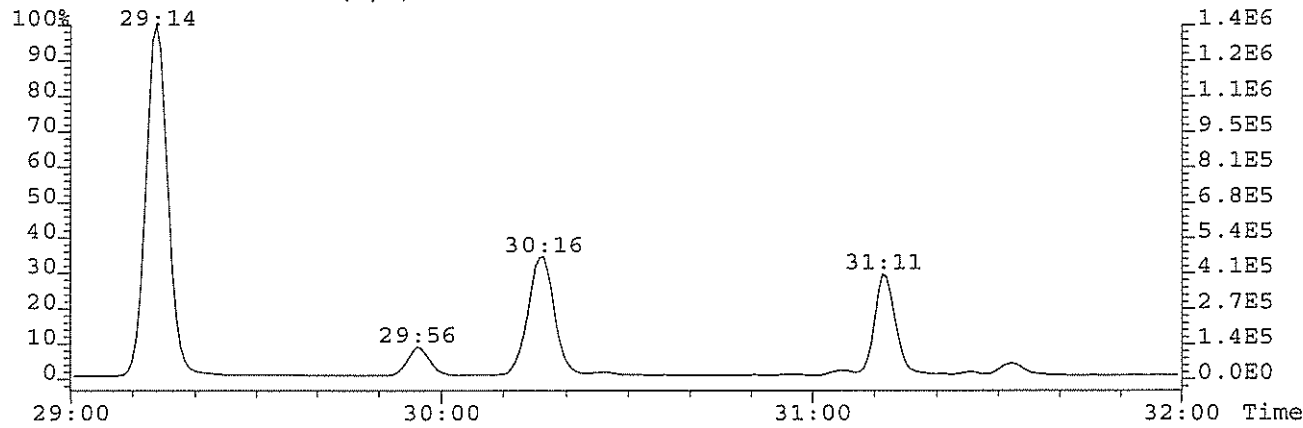
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130712-2 #1-1117 Acq:13-JUL-2013 11:43:10 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#26 File Text:BPX-DXN(4-6DXN) Text:XE13 0945 Exp:BPX04  
373.8207 S:26 F:2 SMO(1,3)



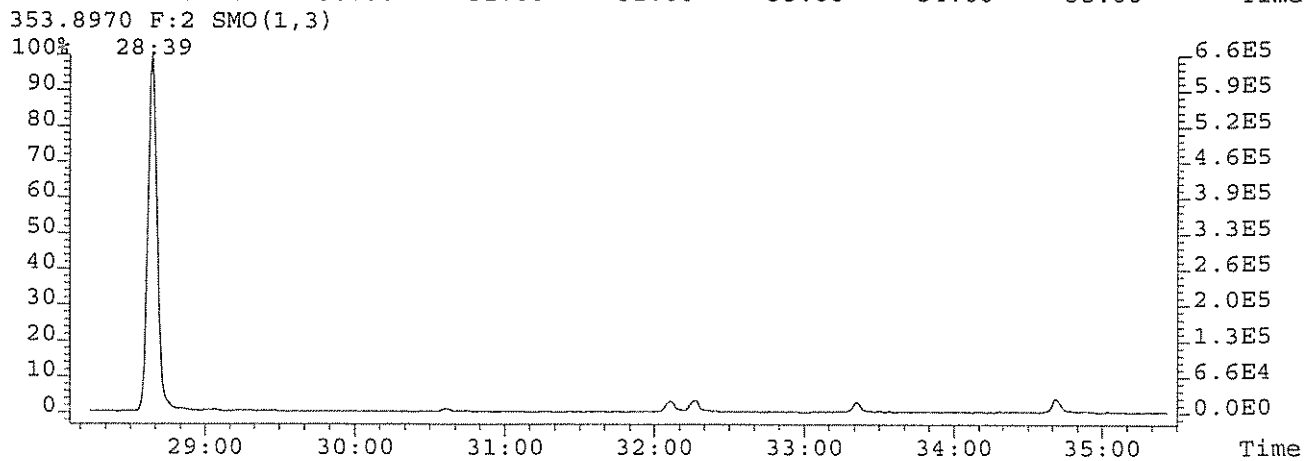
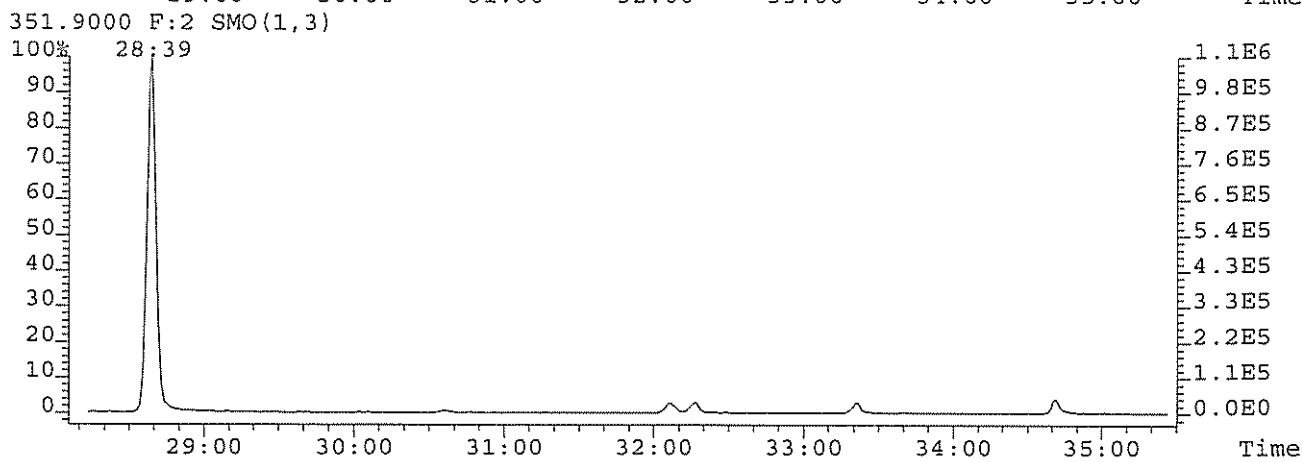
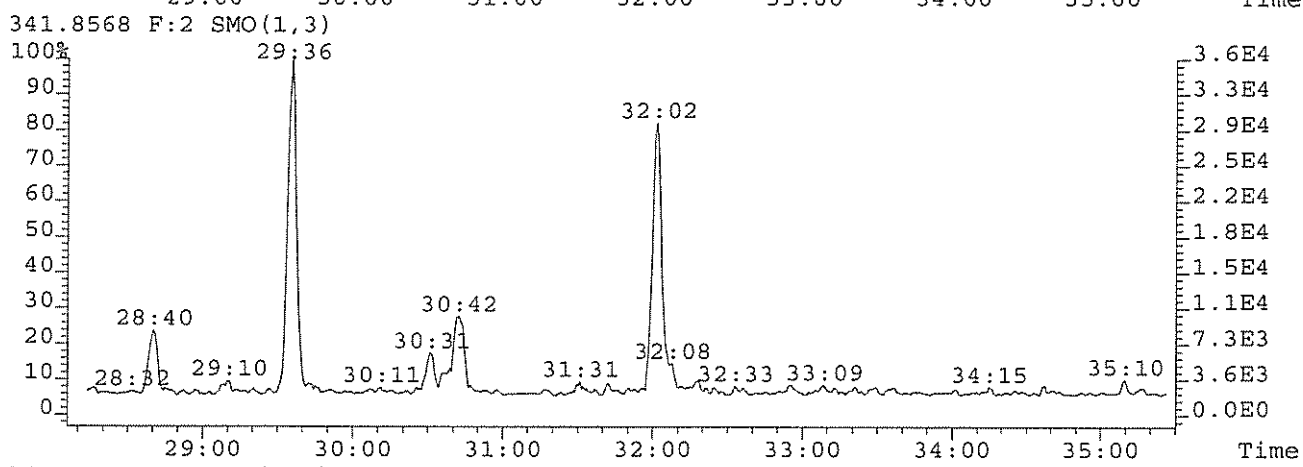
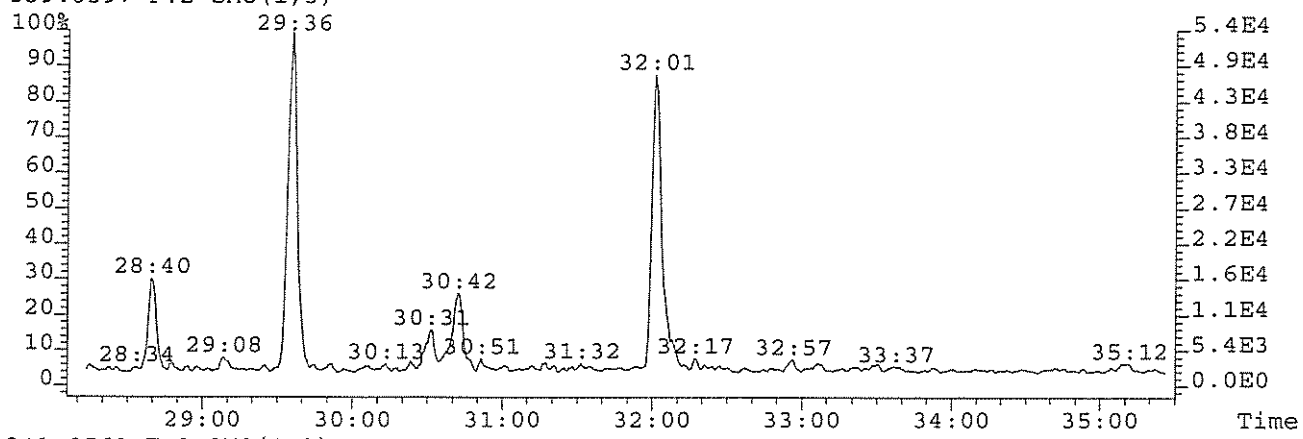
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1117 Acq:13-JUL-2013 11:43:10 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#26 File Text:BPX-DXN(4-6DXN) Text:XE13 0945 Exp:BPX04  
389.8156 S:26 F:2 SMO(1,3)



PCDDsクロマトグラム (6)  
(HxCDDs)

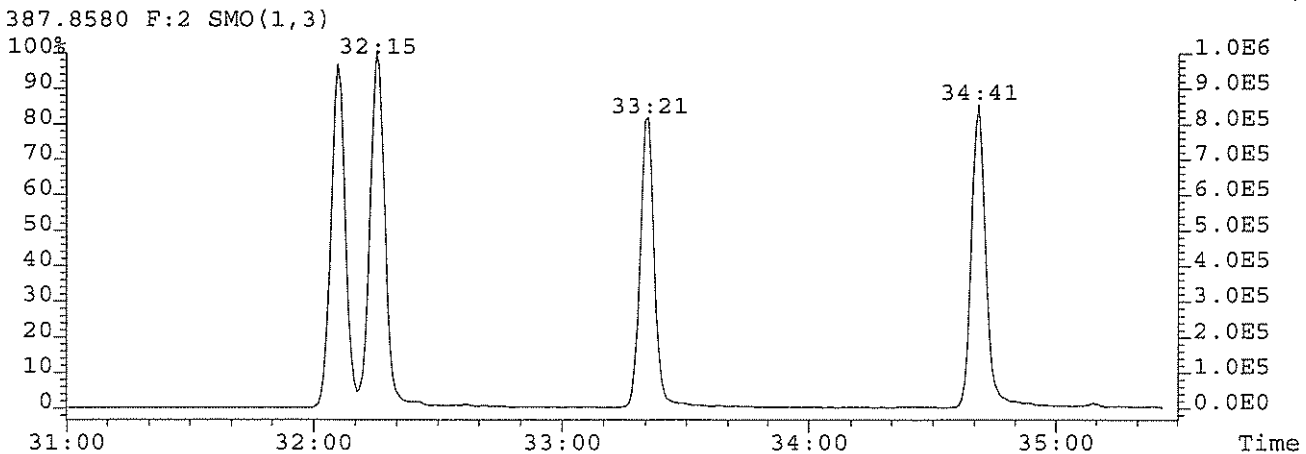
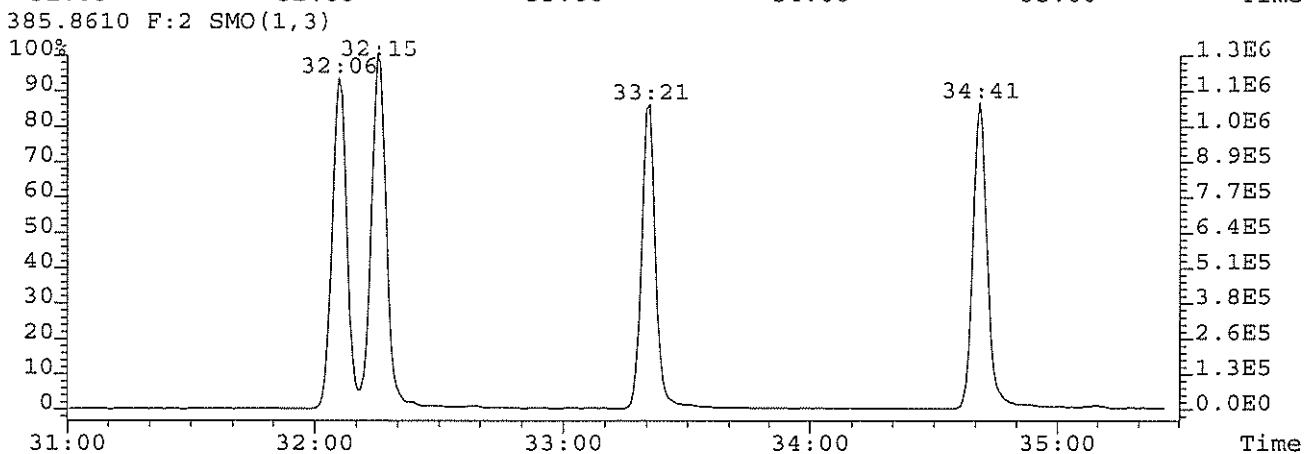
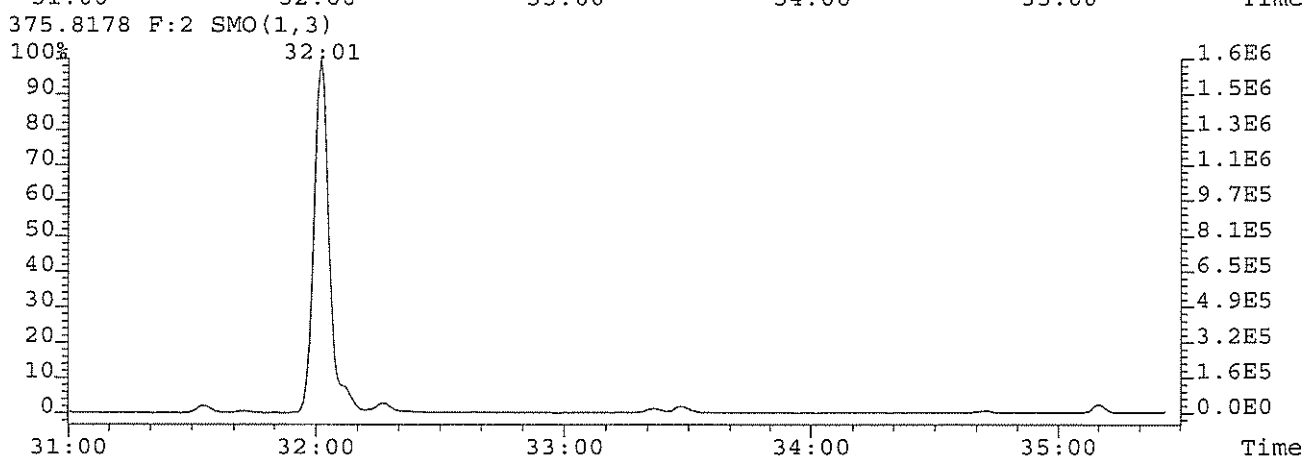
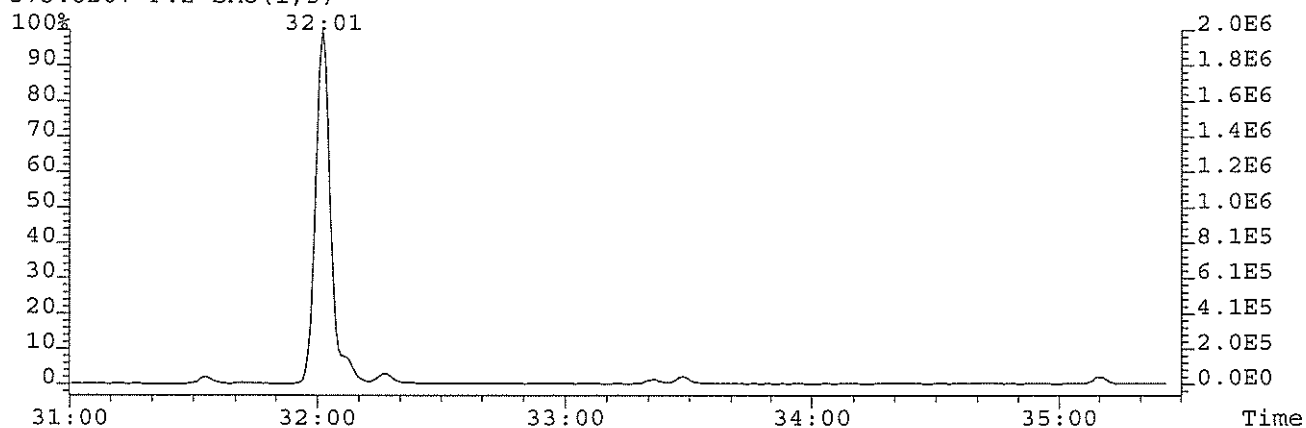
File:130716-2 #1-648 Acq:16-JUL-2013 14:30:00 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(5-8,nP) Text:XE13 0945 3 Exp:RH-PD22



PeCDFsクロマトグラム (7)  
(23478-PeCDF)

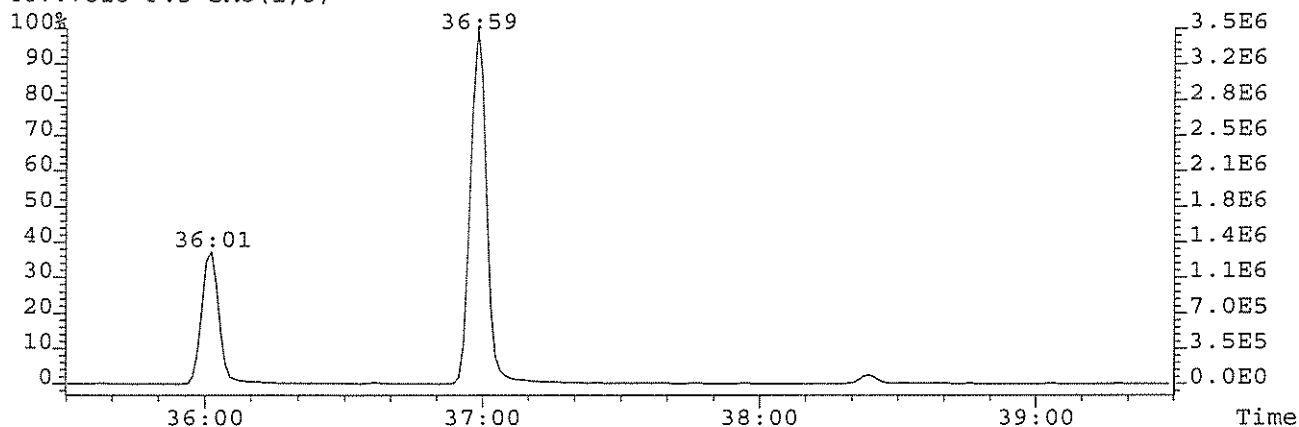


File:130716-2 #1-648 Acq:16-JUL-2013 14:30:00 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(5-8,nP) Text:XE13 0945 3 Exp:RH-PD22  
373.8207 F:2 SMO(1,3)

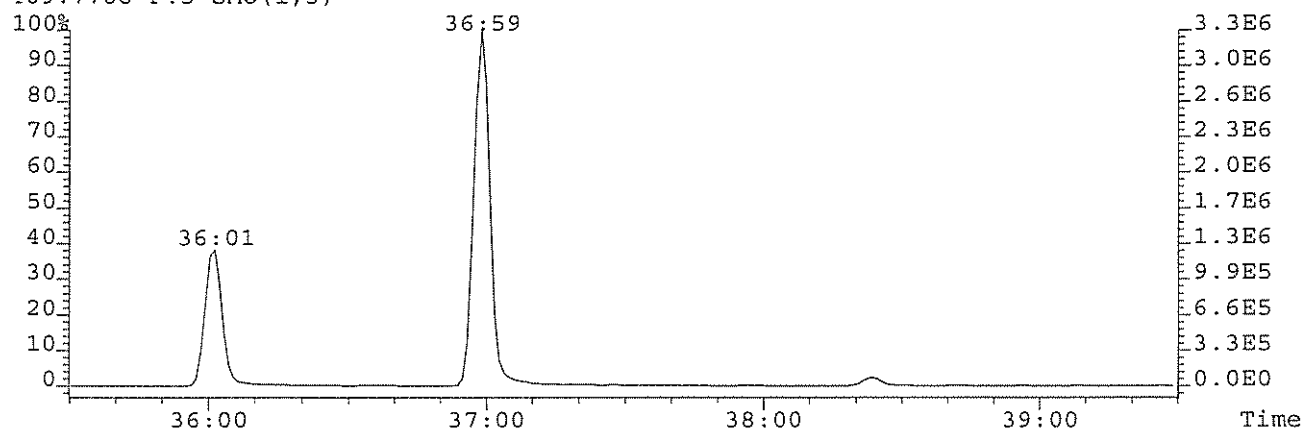


HxCDFsクロマトグラム (8)  
(123789-HxCDF)

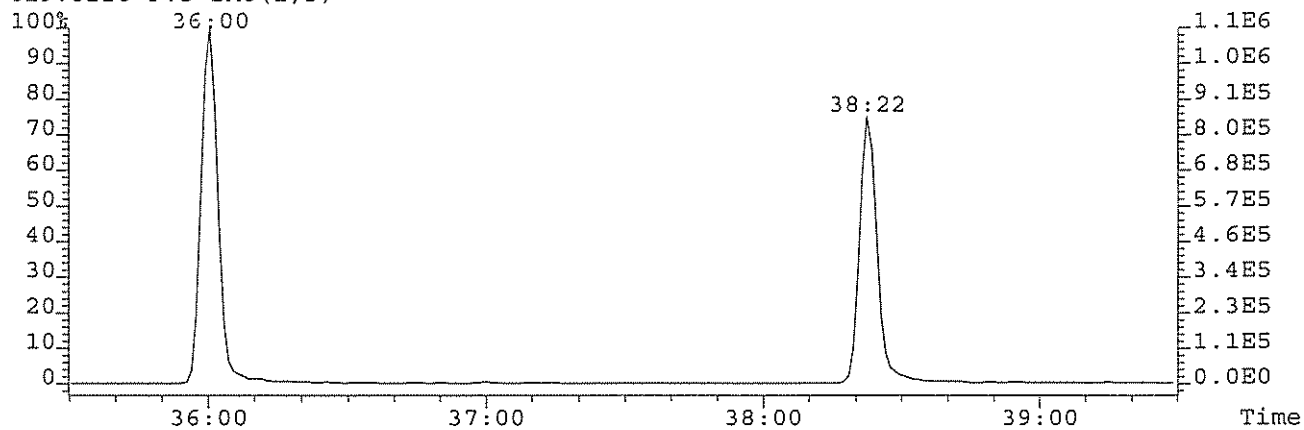
File:130716-2 #1-562 Acq:16-JUL-2013 14:30:00 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(5-8,nP) Text:XE13 0945 3 Exp:RH-PD22  
407.7818 F:3 SMO(1,3)



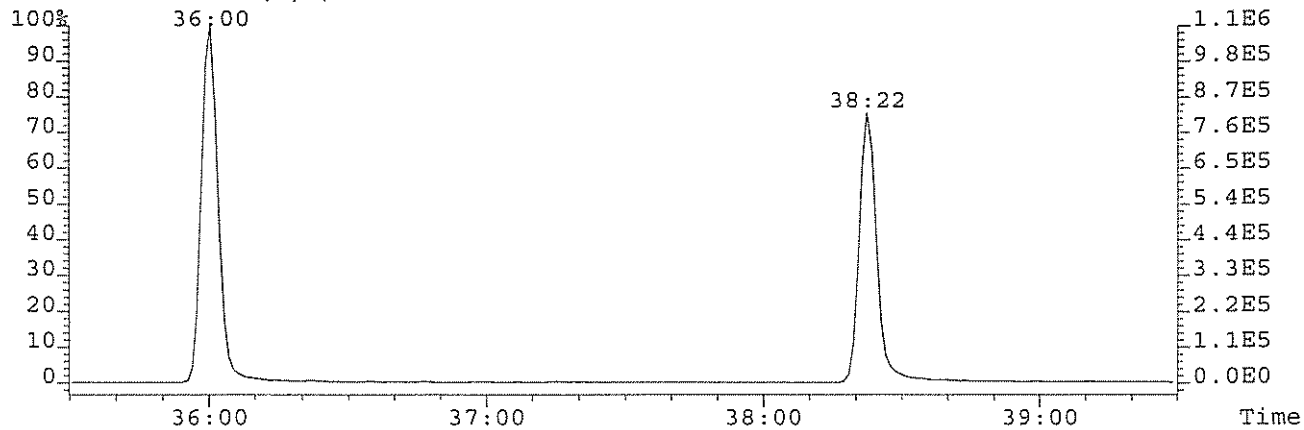
409.7788 F:3 SMO(1,3)



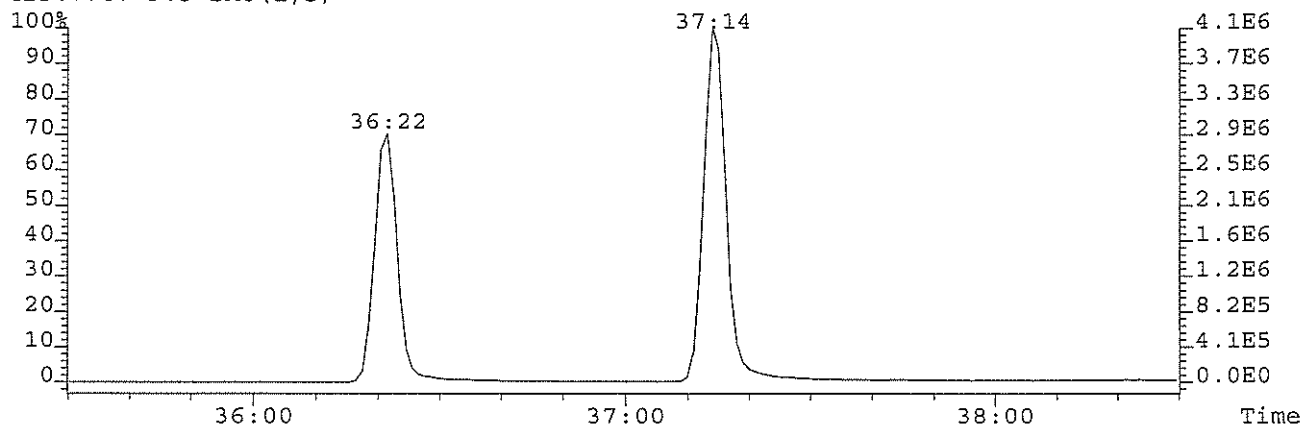
419.8220 F:3 SMO(1,3)



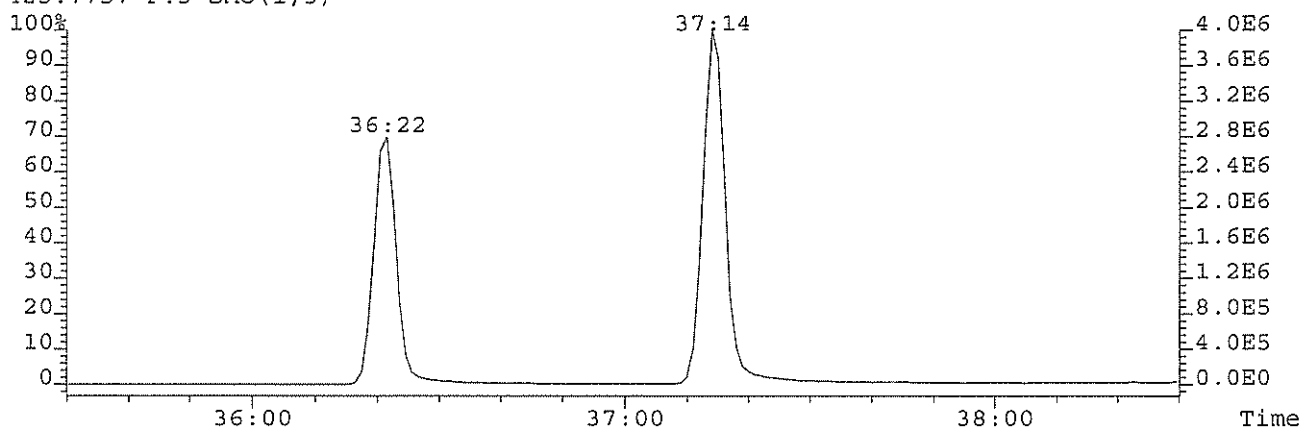
421.8191 F:3 SMO(1,3)



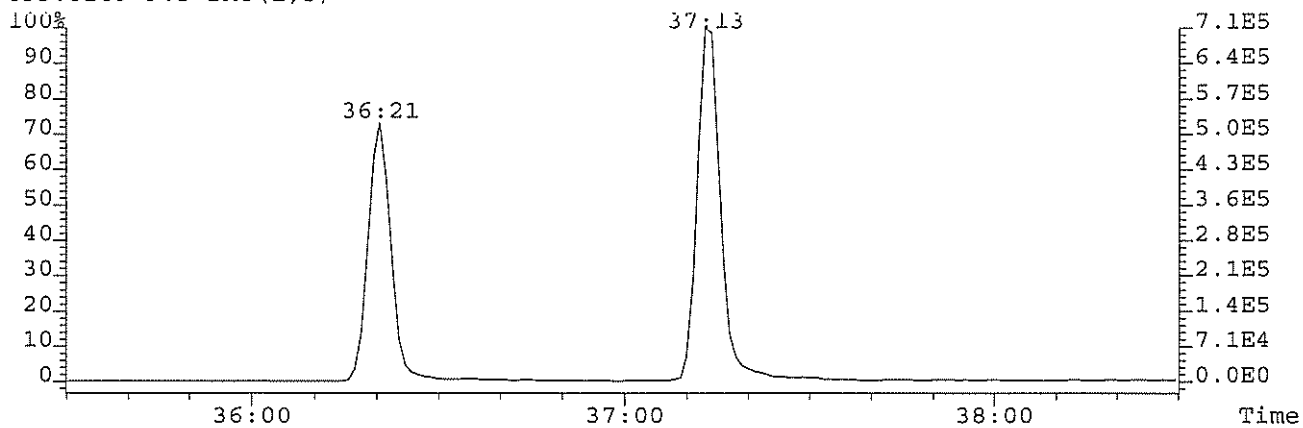
File:130716-2 #1-562 Acq:16-JUL-2013 14:30:00 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(5-8,nP) Text:XE13 0945 3 Exp:RH-PD22  
423.7767 F:3 SMO(1,3)



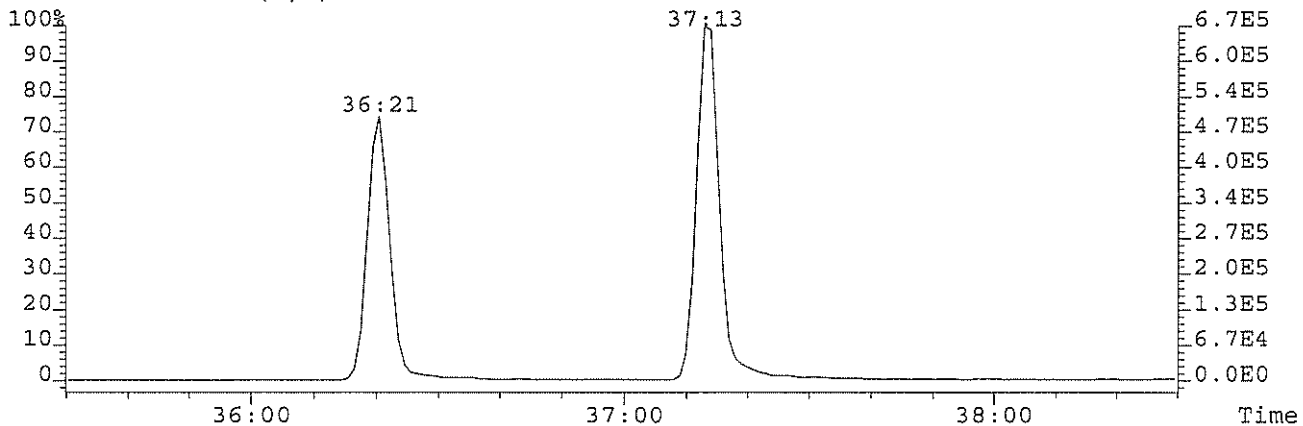
425.7737 F:3 SMO(1,3)



435.8169 F:3 SMO(1,3)

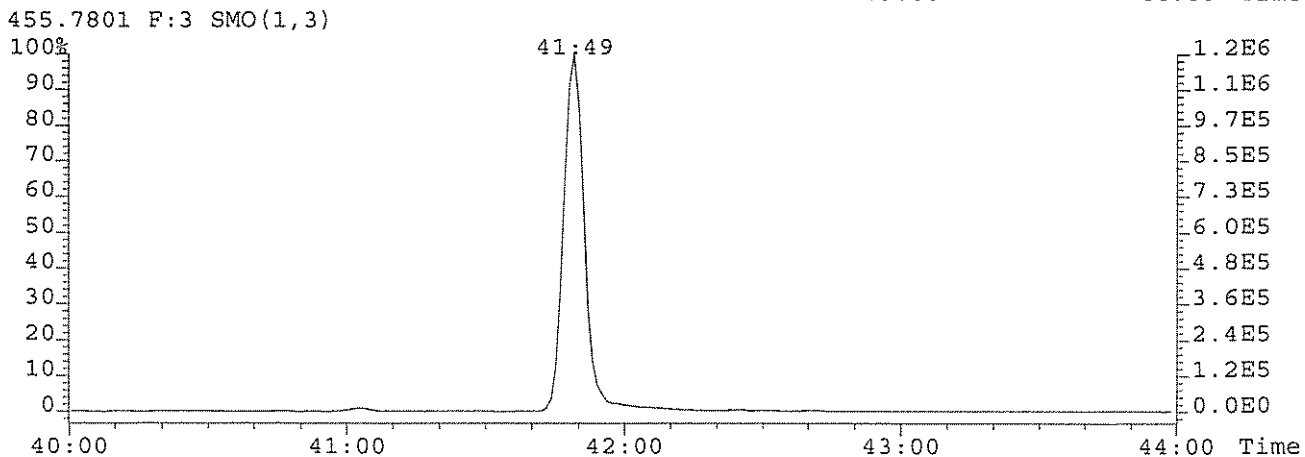
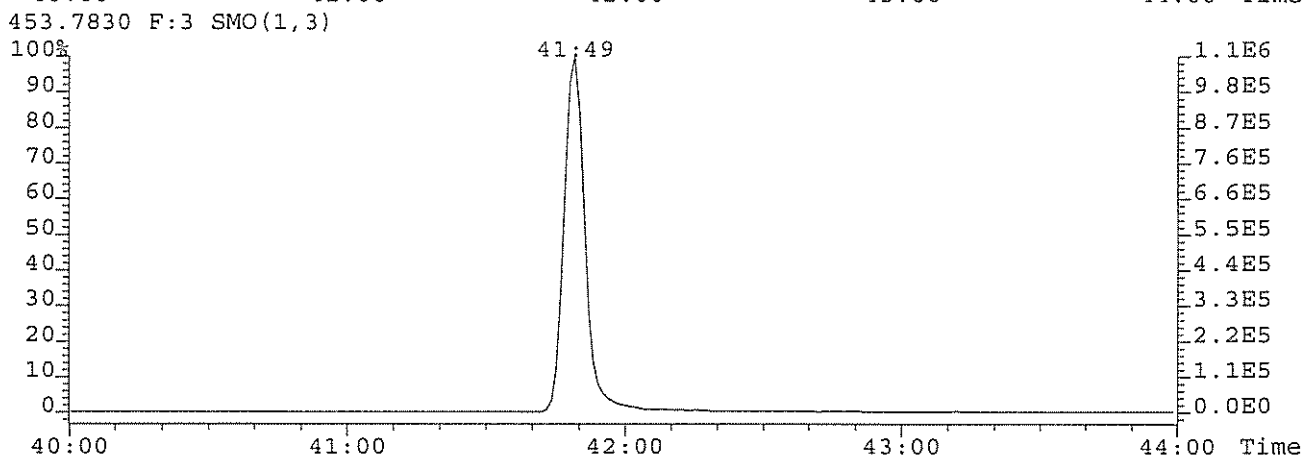
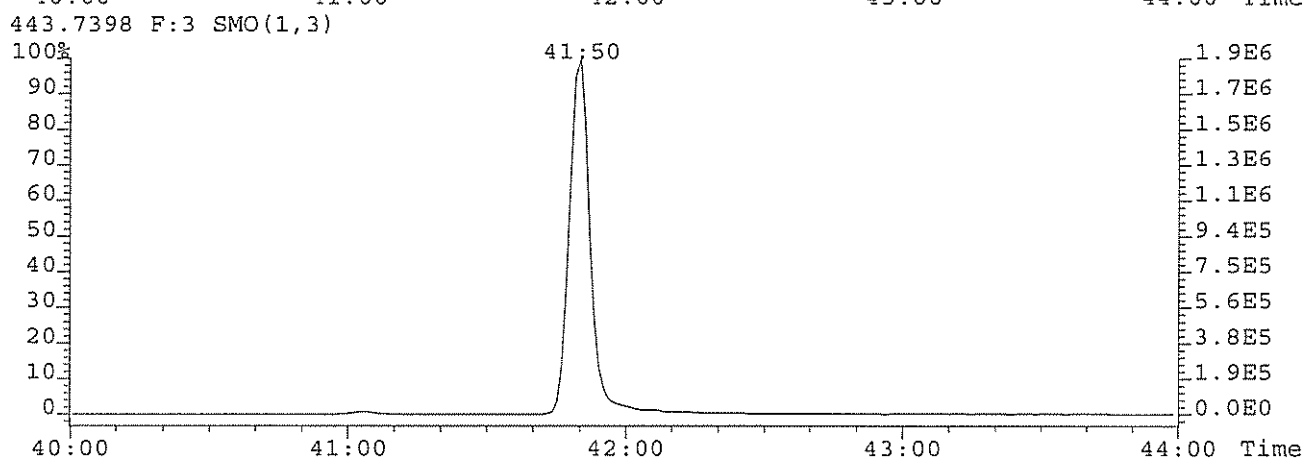
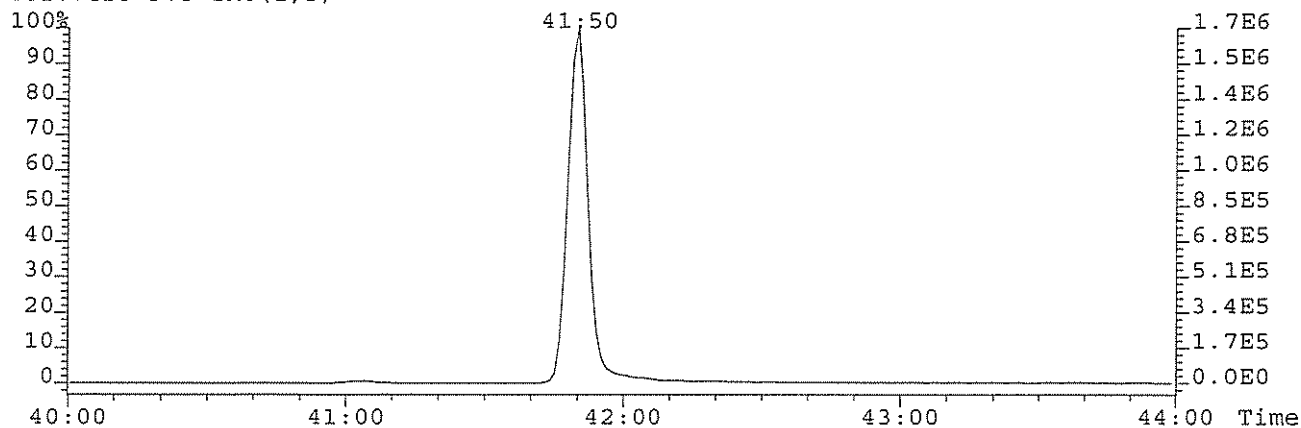


437.8140 F:3 SMO(1,3)



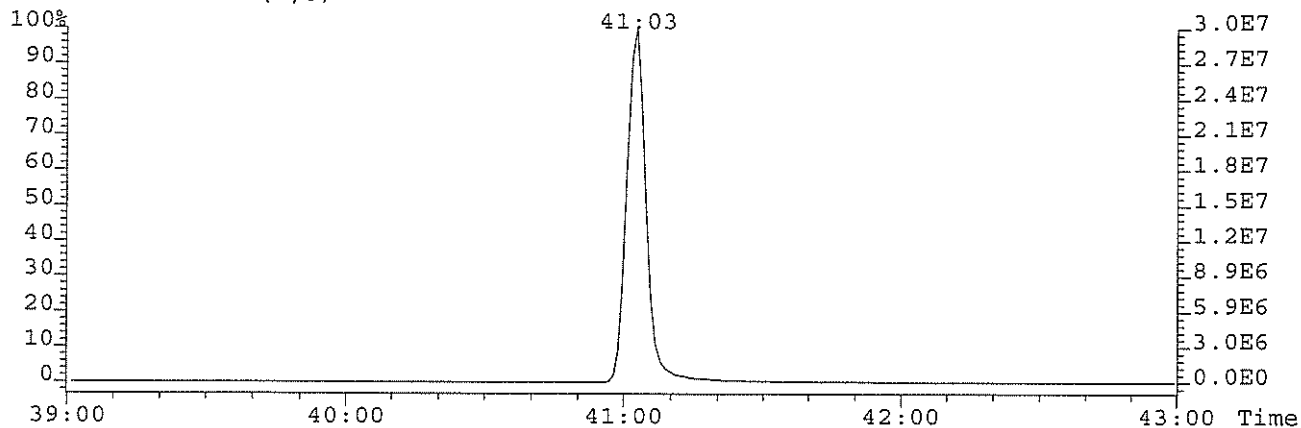
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130716-2 #1-562 Acq:16-JUL-2013 14:30:00 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(5-8,nP) Text:XE13 0945 3 Exp:RH-PD22  
441.7428 F:3 SMO(1,3)

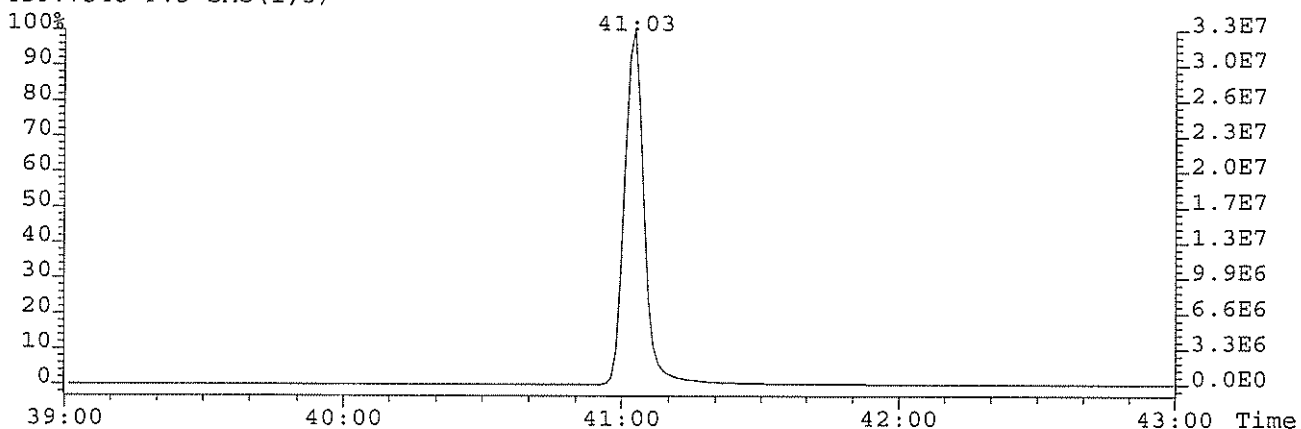


PCDFsクロマトグラム (11)  
(OCDF)

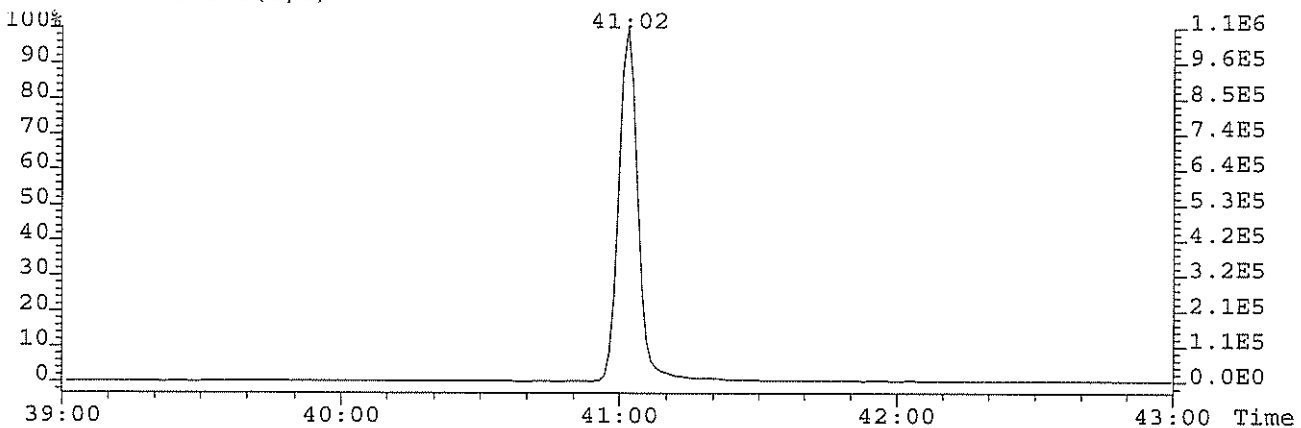
File:130716-2 #1-562 Acq:16-JUL-2013 14:30:00 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(5-8,nP) Text:XE13 0945 3 Exp:RH-PD22  
457.7377 F:3 SMO(1,3)



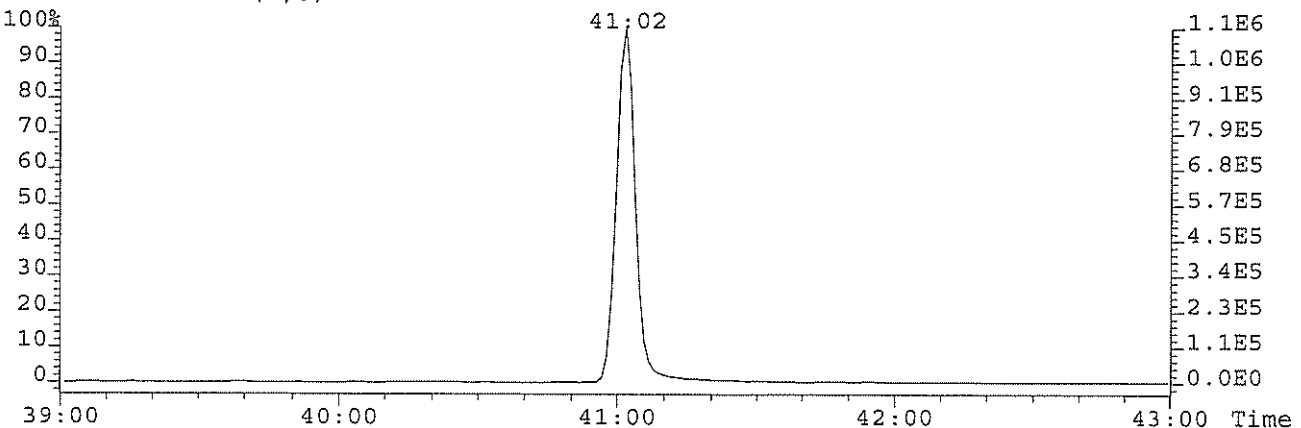
459.7348 F:3 SMO(1,3)



469.7780 F:3 SMO(1,3)

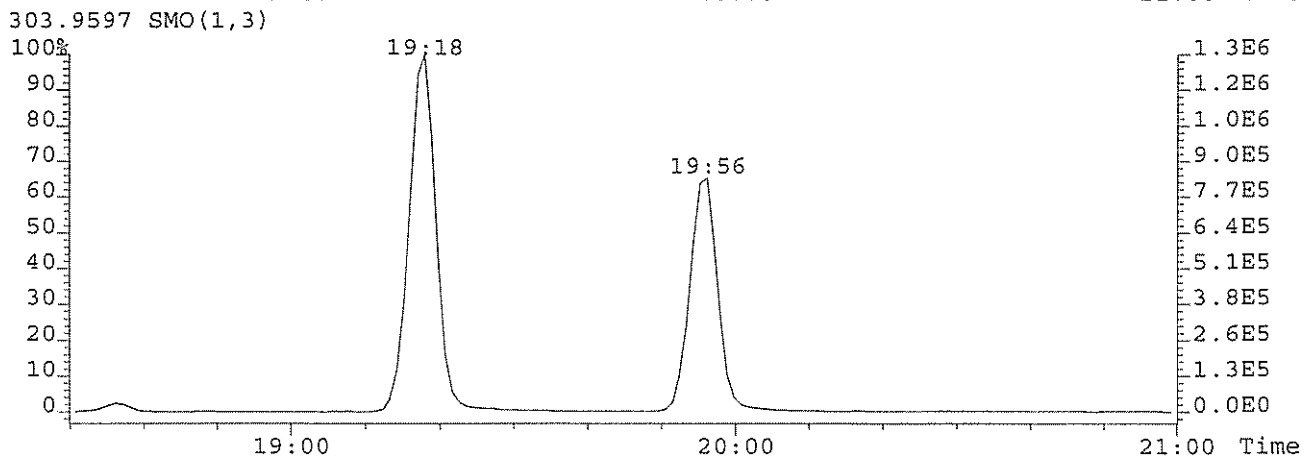
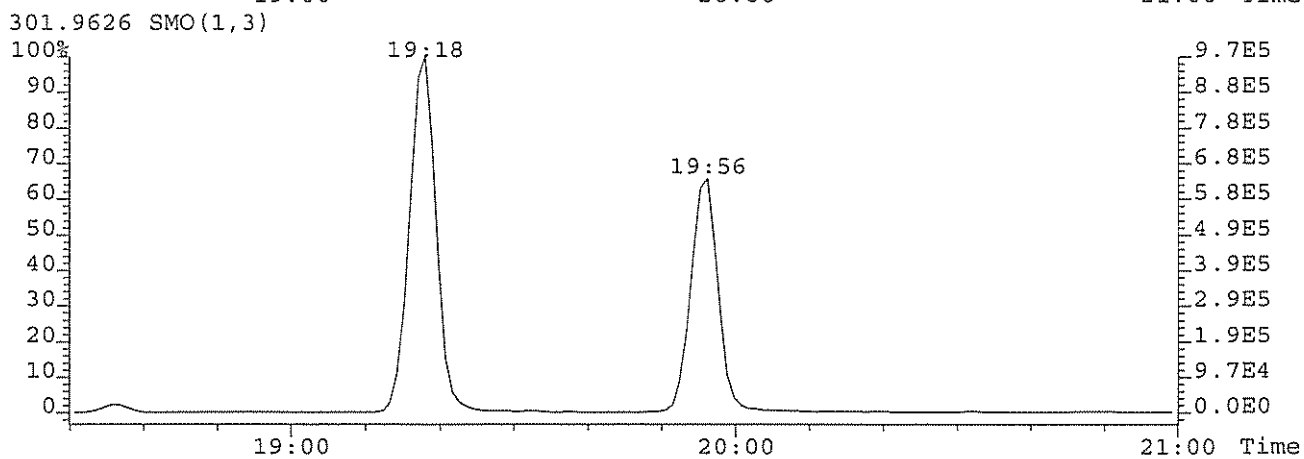
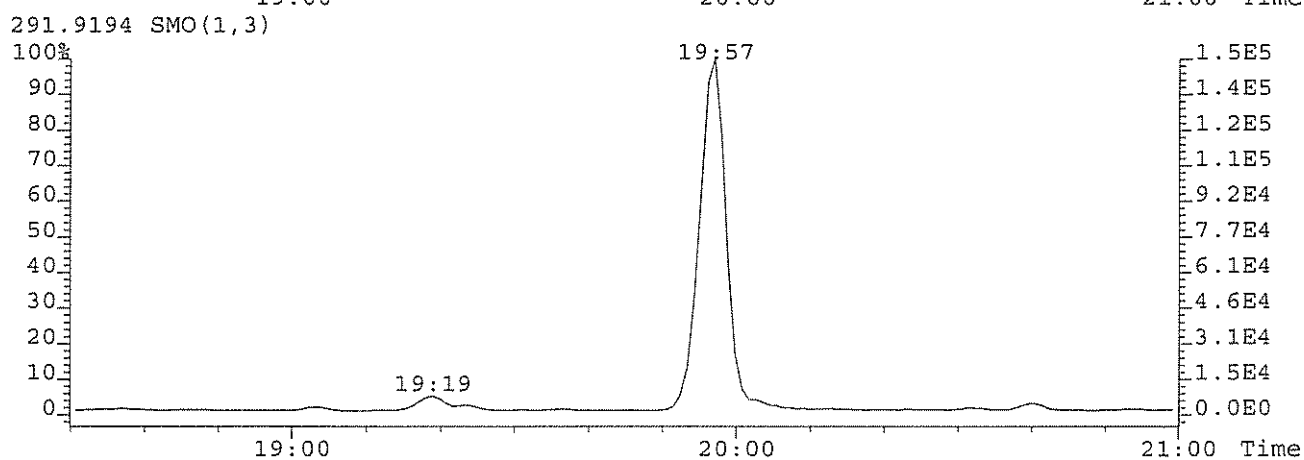
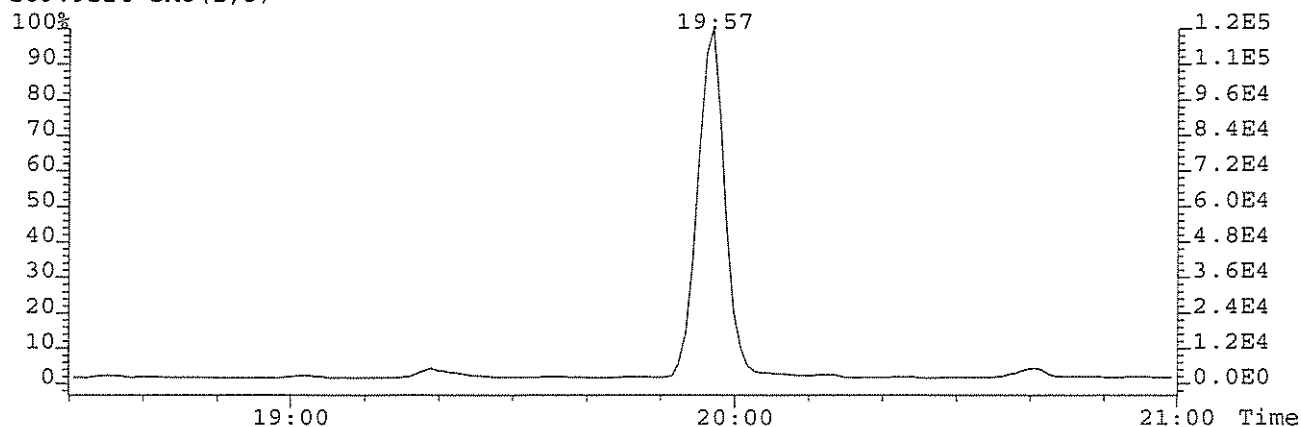


471.7750 F:3 SMO(1,3)



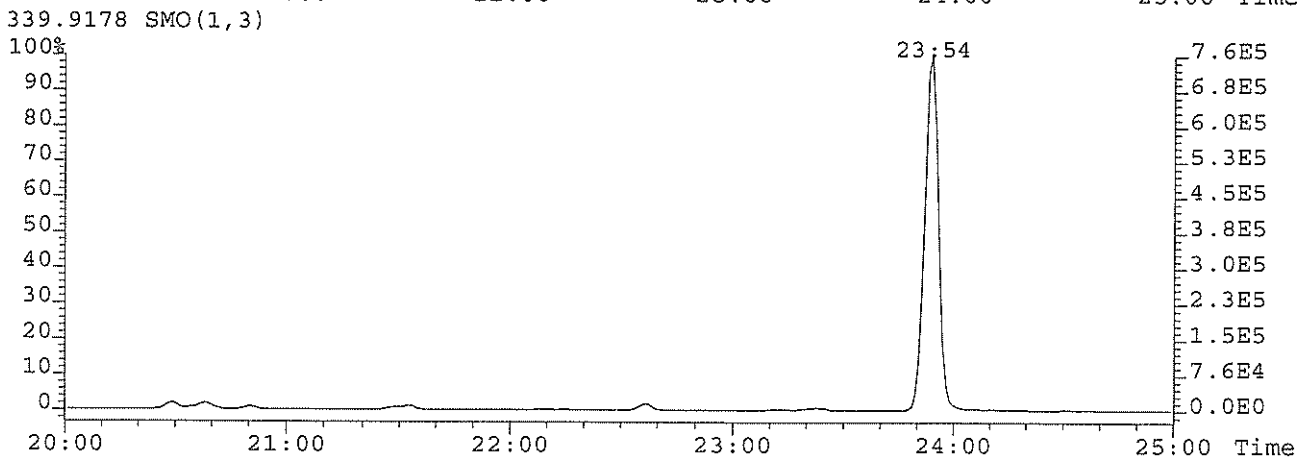
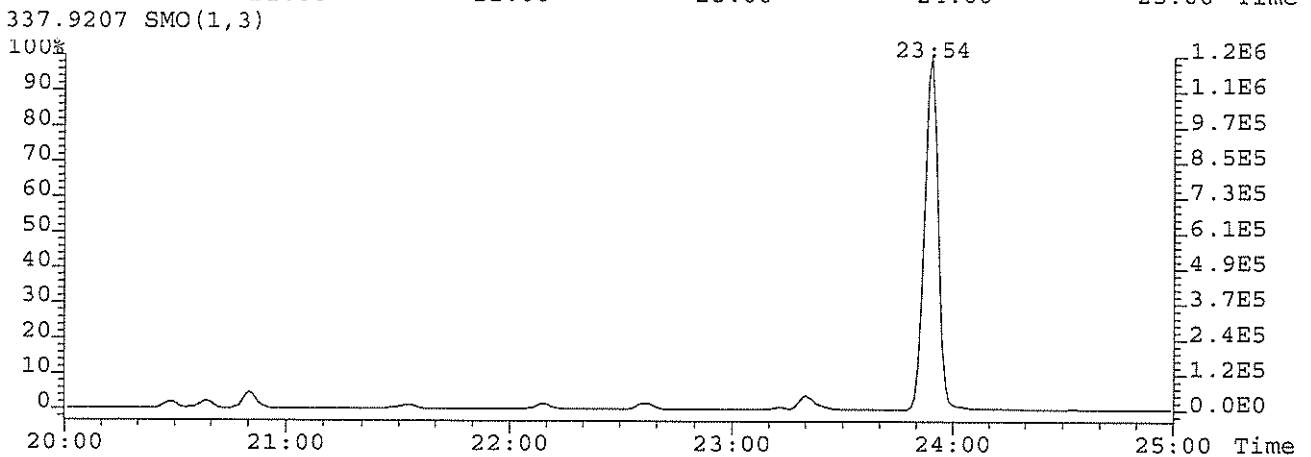
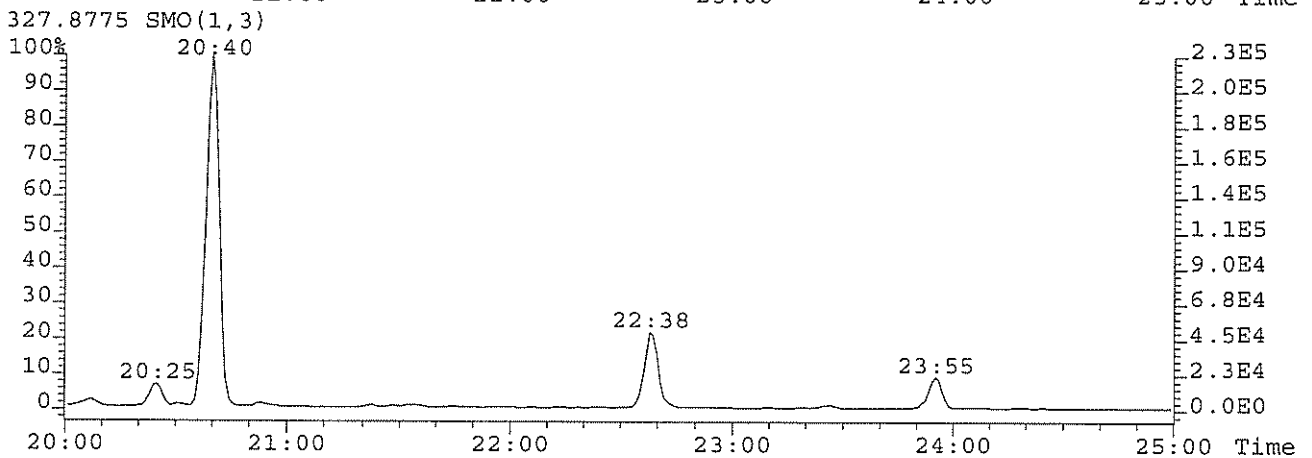
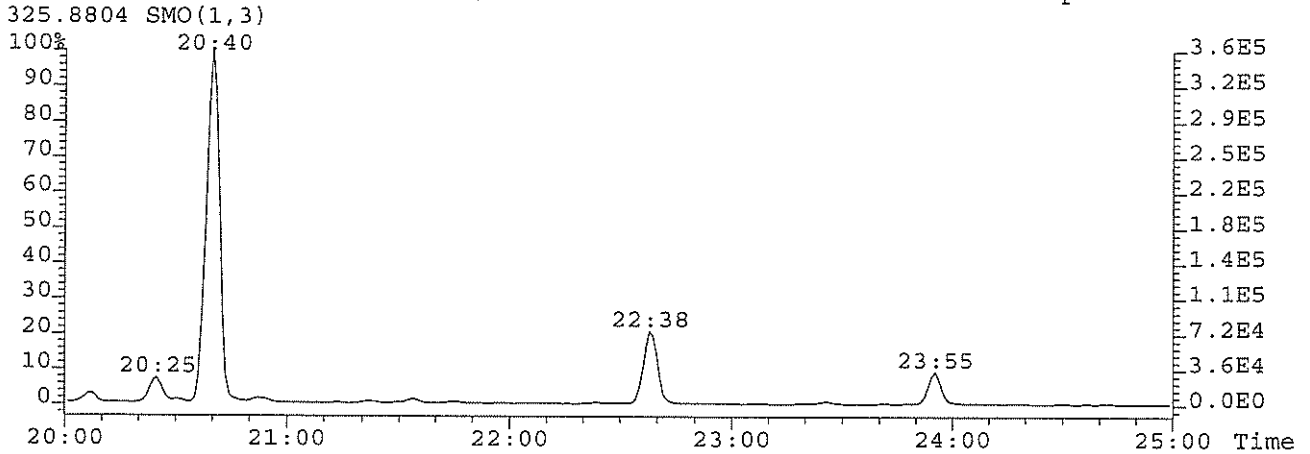
PCDDsクロマトグラム (12)  
(OCDD)

File:130716-2 #1-1431 Acq:16-JUL-2013 14:30:00 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(5-8,nP) Text:XE13 0945 3 Exp:RH-PD22  
289.9224 SMO(1,3)



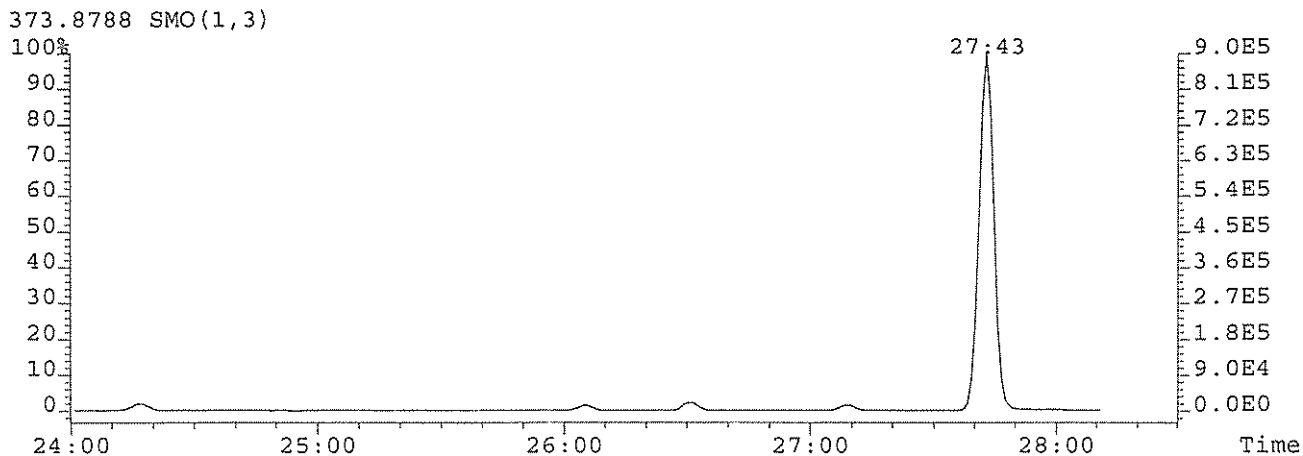
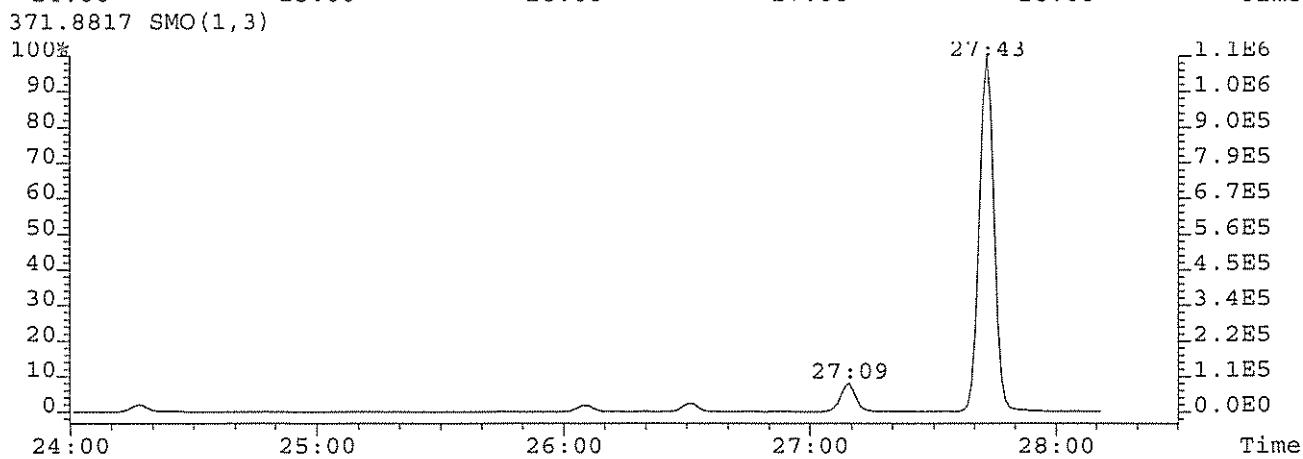
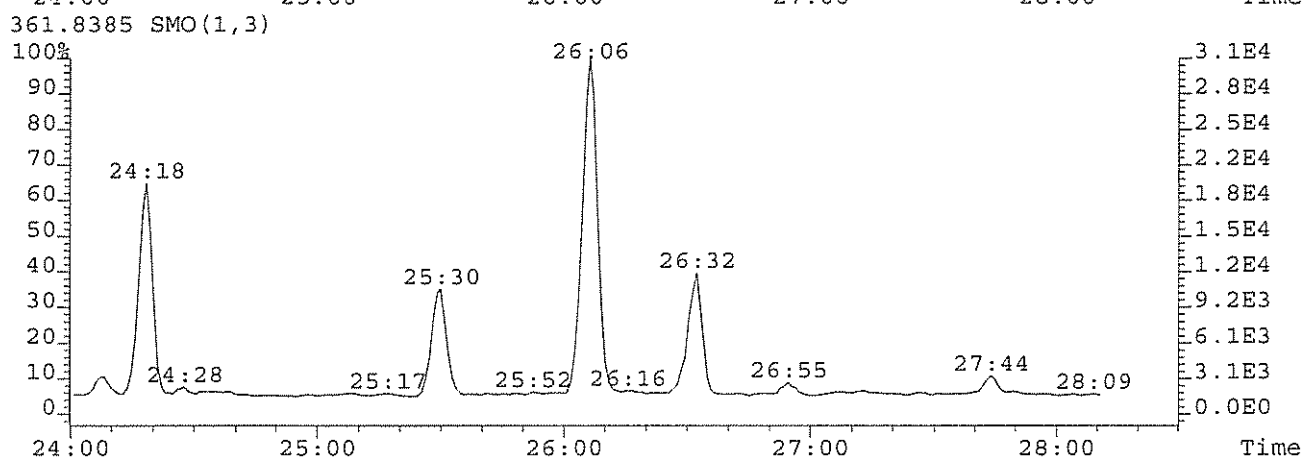
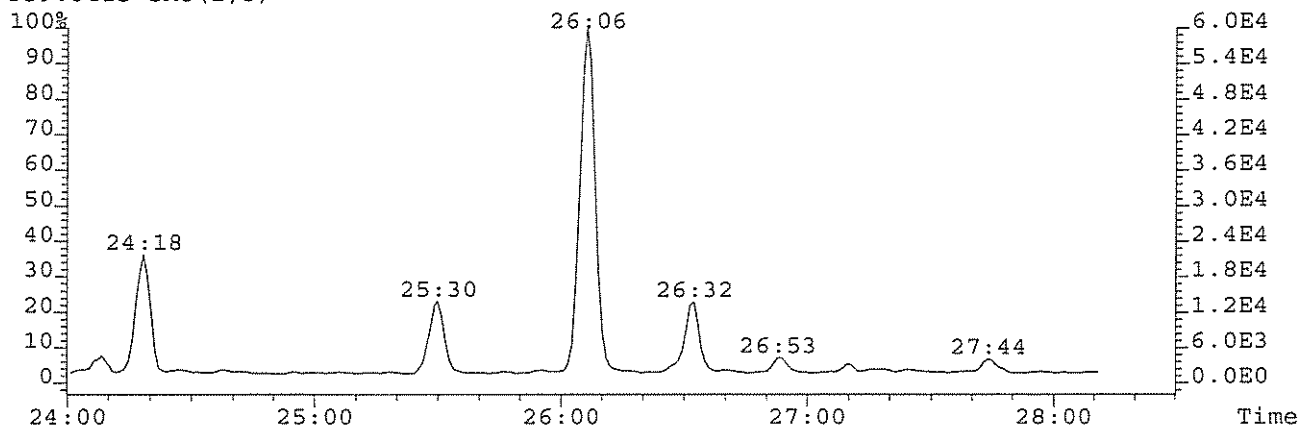
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130716-2 #1-1431 Acq:16-JUL-2013 14:30:00 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(5-8,nP) Text:XE13 0945 3 Exp:RH-PD22



DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130716-2 #1-1431 Acq:16-JUL-2013 14:30:00 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(5-8,nP) Text:XE13 0945 3 Exp:RH-PD22  
359.8415 SMO(1,3)

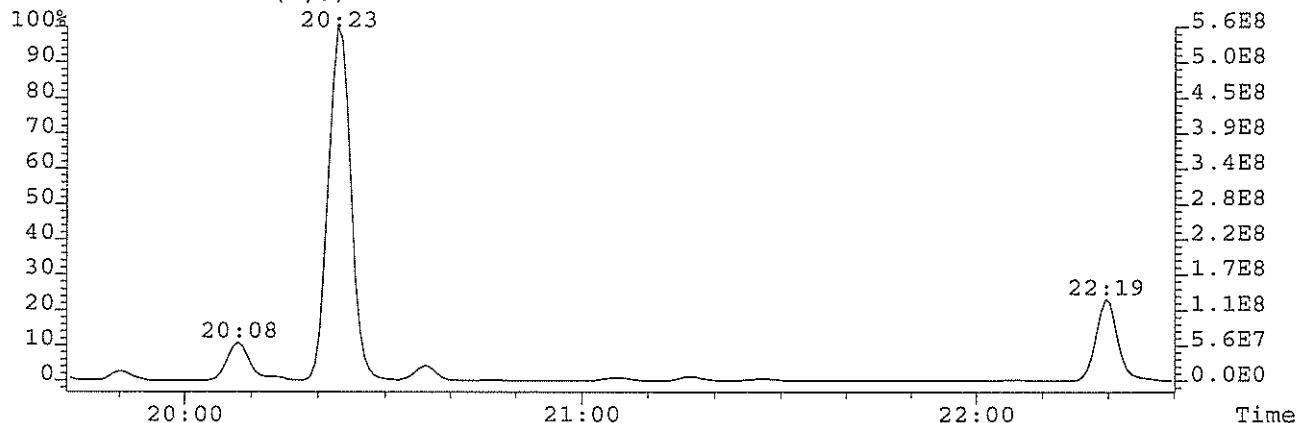


DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

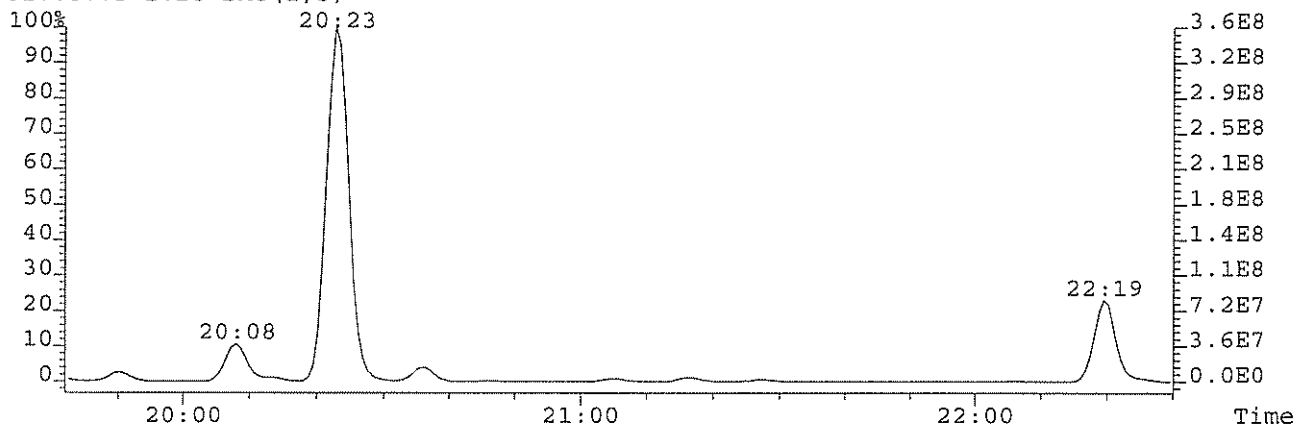


File:130711-2 #1-2897 Acq:12-JUL-2013 07:22:14 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(mP) Text:XE13 0945 2 Exp:RH-MP11

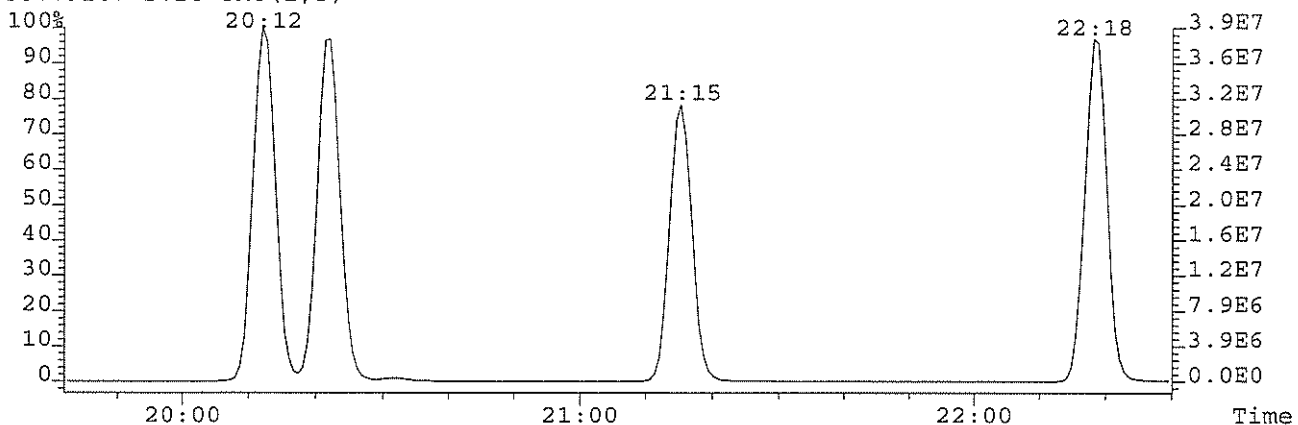
325.8804 S:20 SMO(1,3)



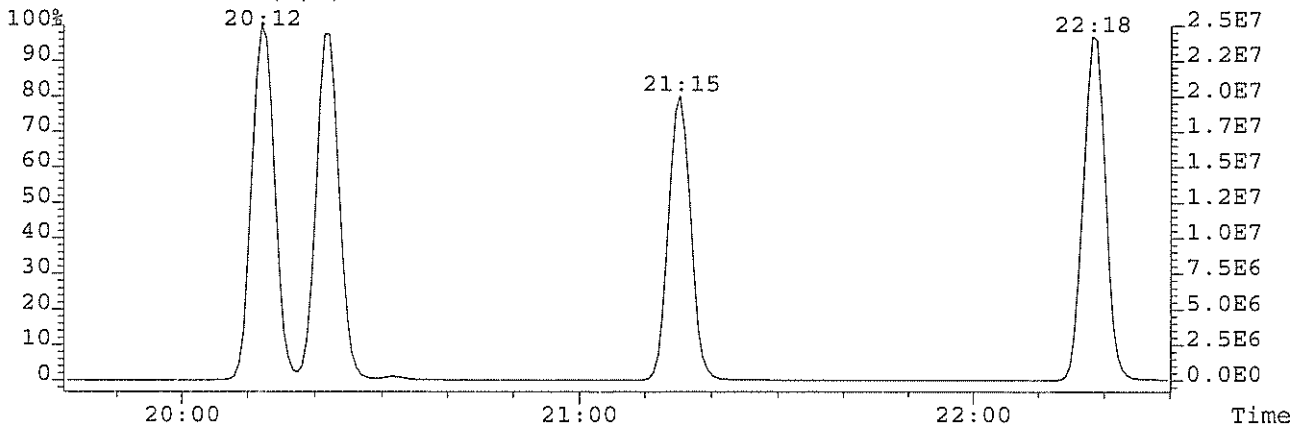
327.8775 S:20 SMO(1,3)



337.9207 S:20 SMO(1,3)

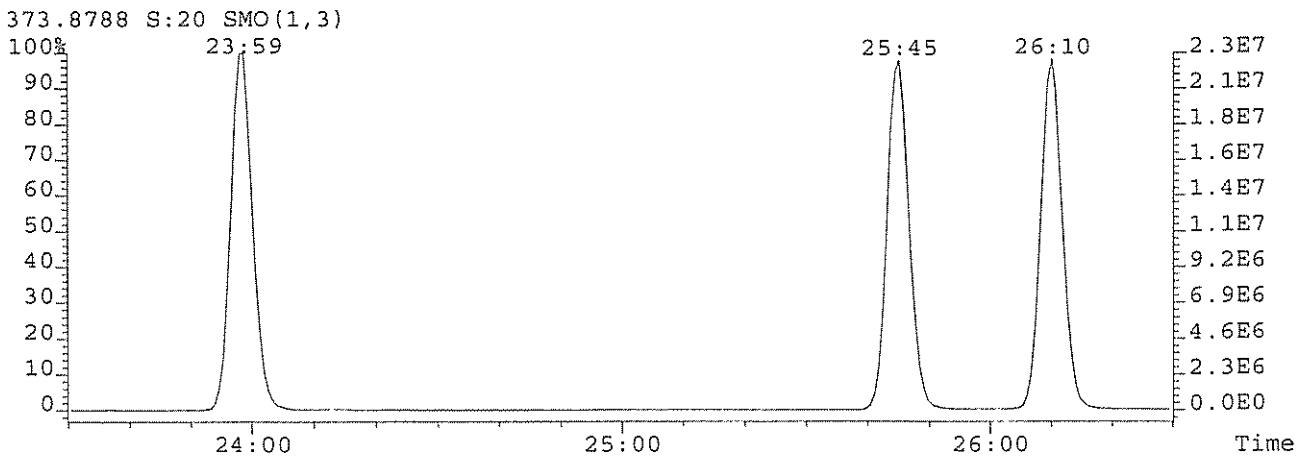
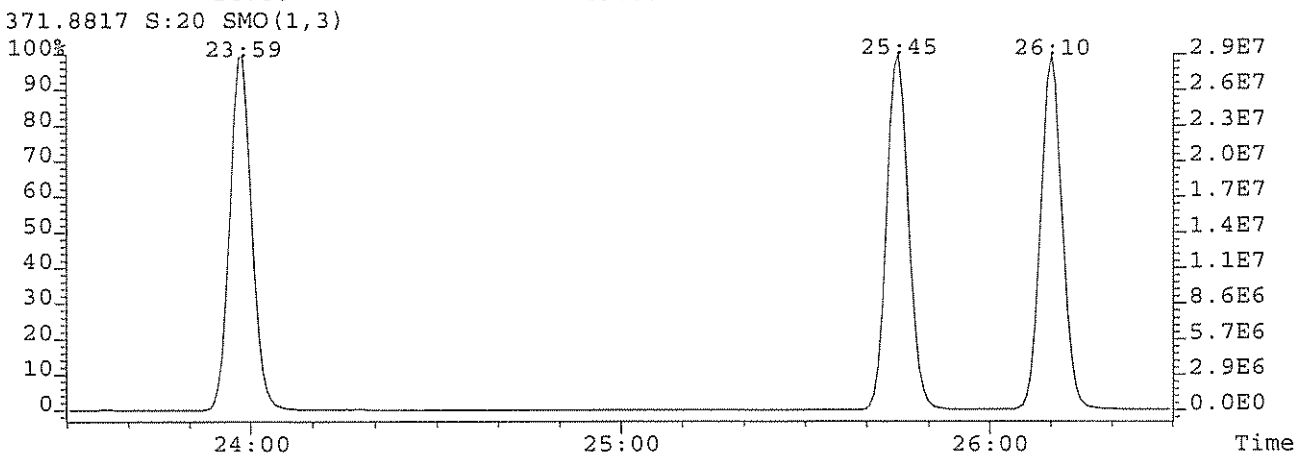
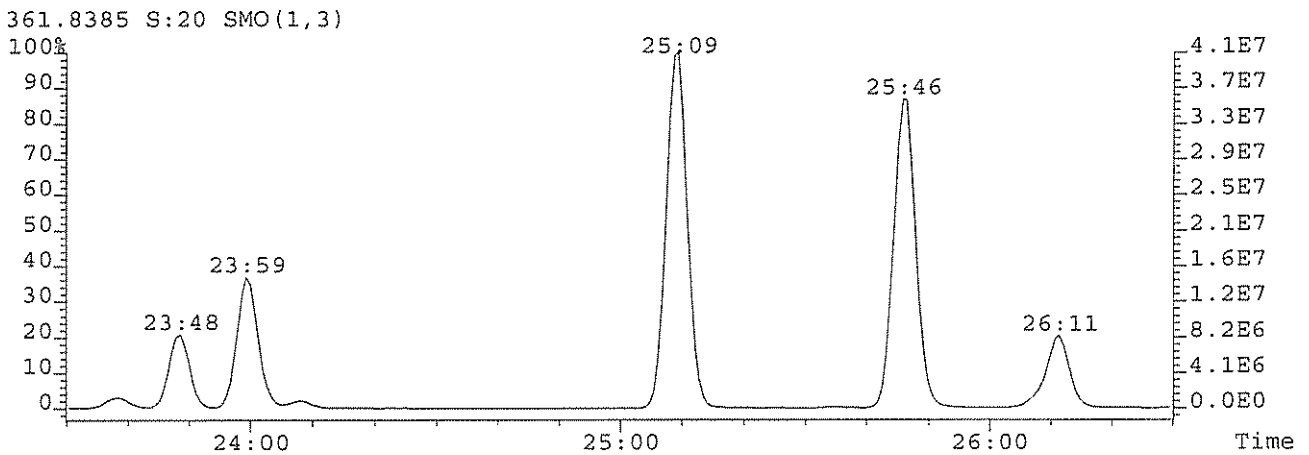
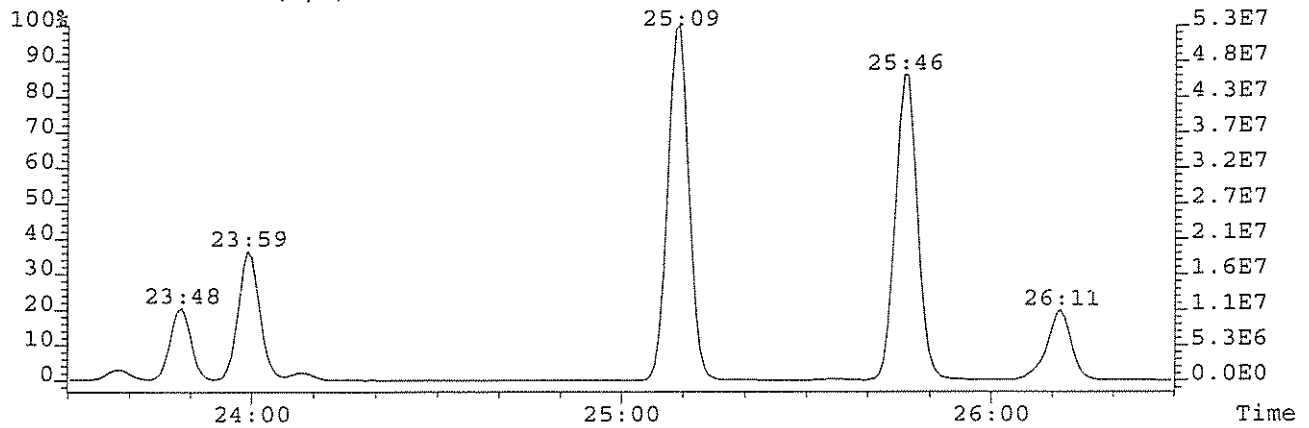


339.9178 S:20 SMO(1,3)



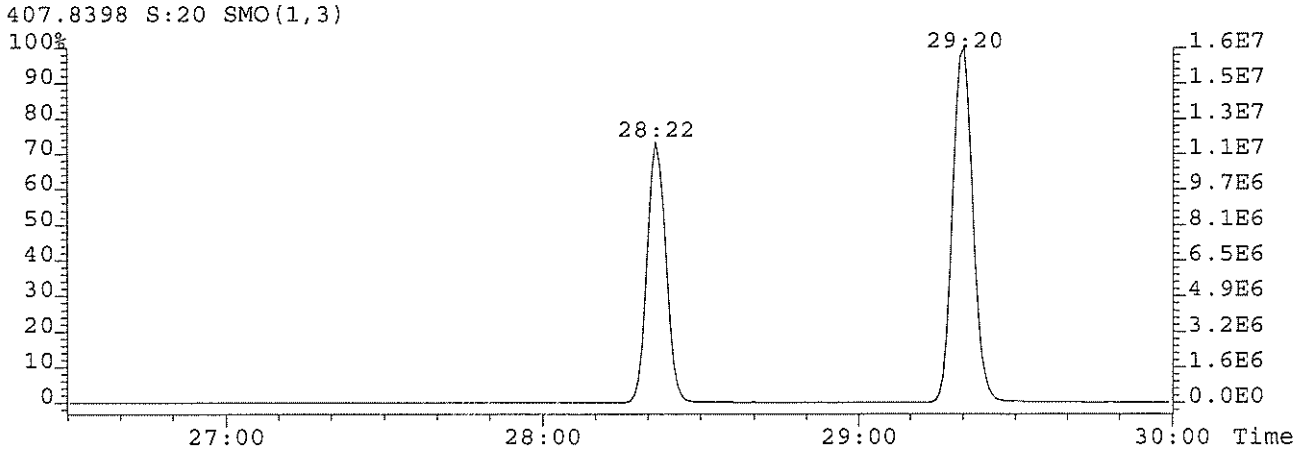
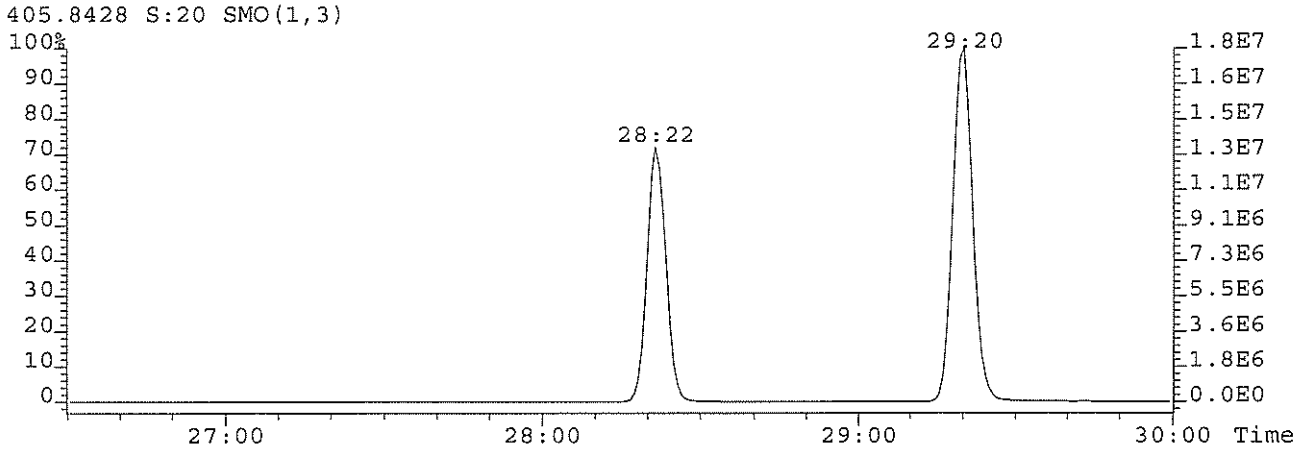
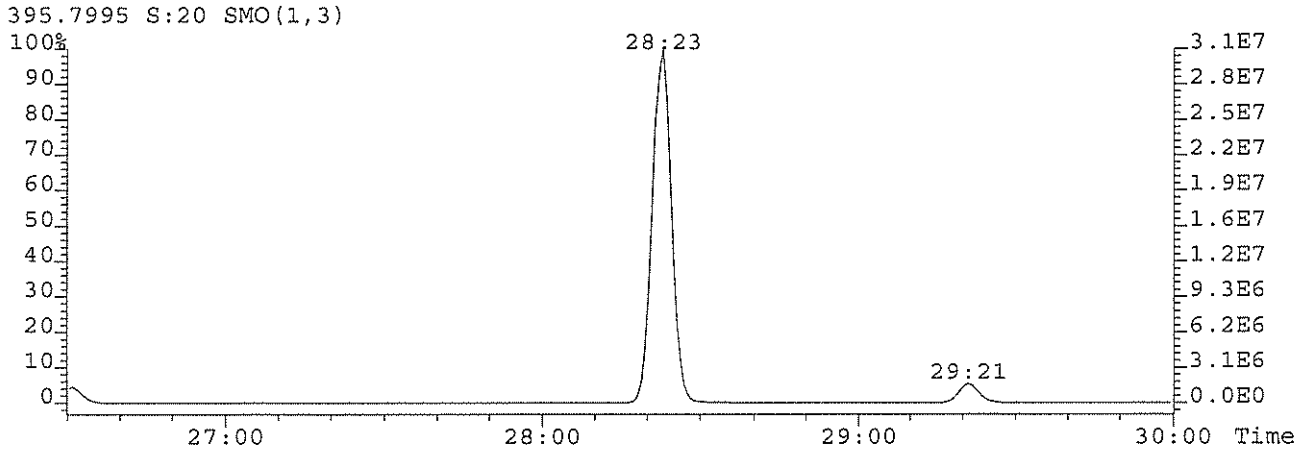
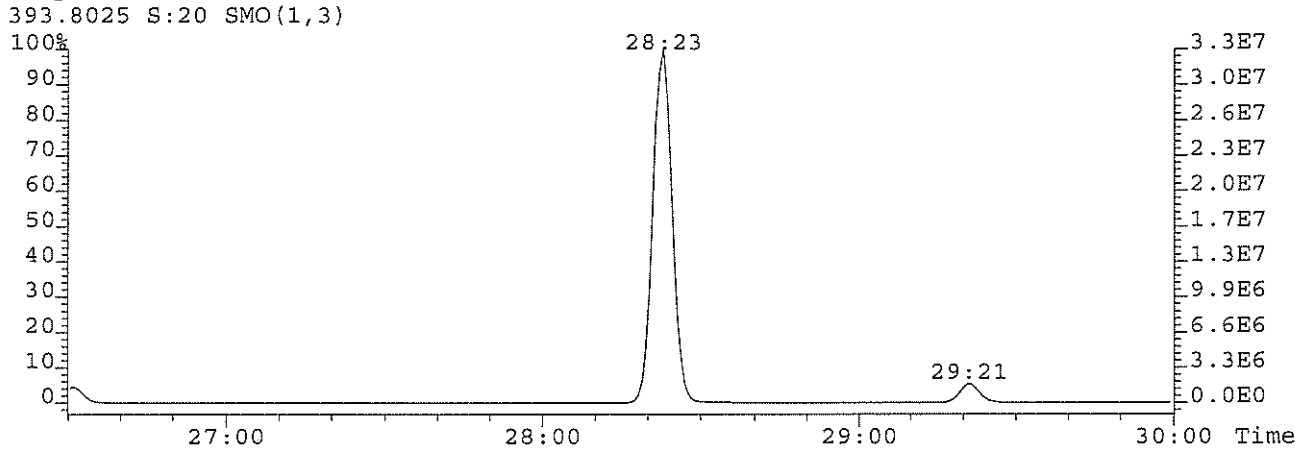
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130711-2 #1-2897 Acq:12-JUL-2013 07:22:14 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(mP) Text:XE13 0945 2 Exp:RH-MP11  
359.8415 S:20 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130711-2 #1-2897 Acq:12-JUL-2013 07:22:14 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(mP) Text:XE13 0945 2 Exp:RH-MP11

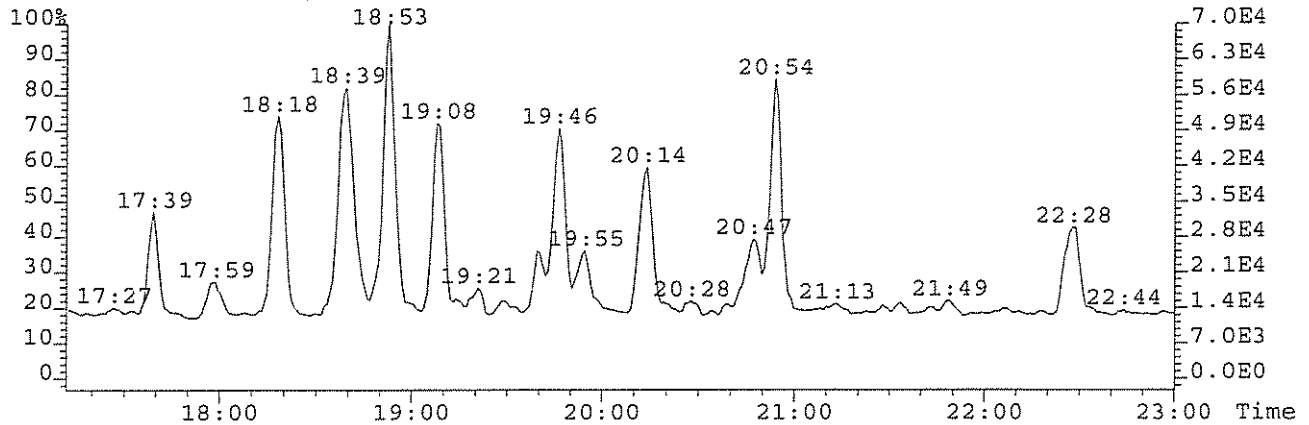


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

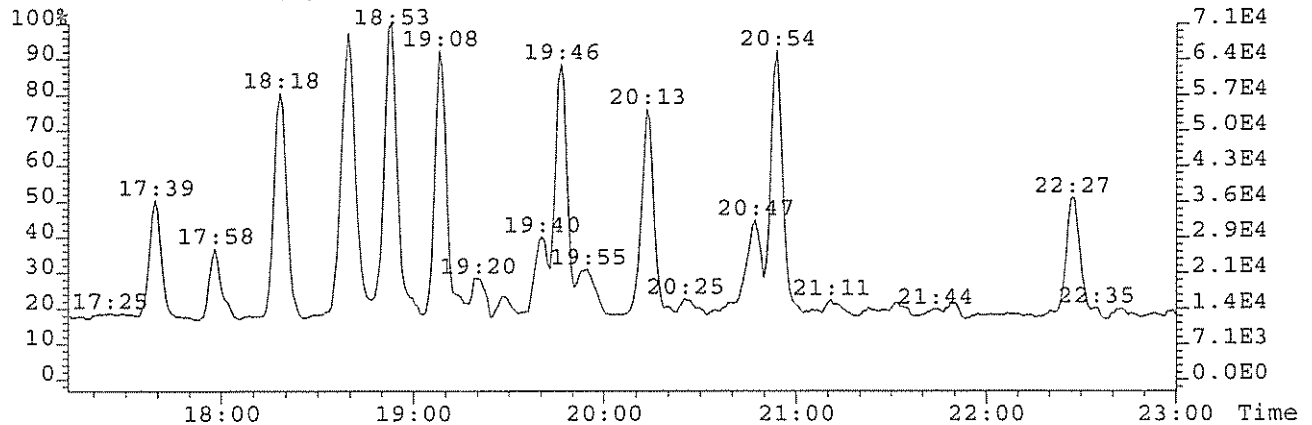
試料管理番号	XE 130946
採取場所	旧嘉手納飛行場
試料名	埋設地点土壌

File:130712-2 #1-1578 Acq:13-JUL-2013 12:27:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#27 File Text:BPX-DXN(4-6DXN) Text:XE13 0946 Exp:BPX04

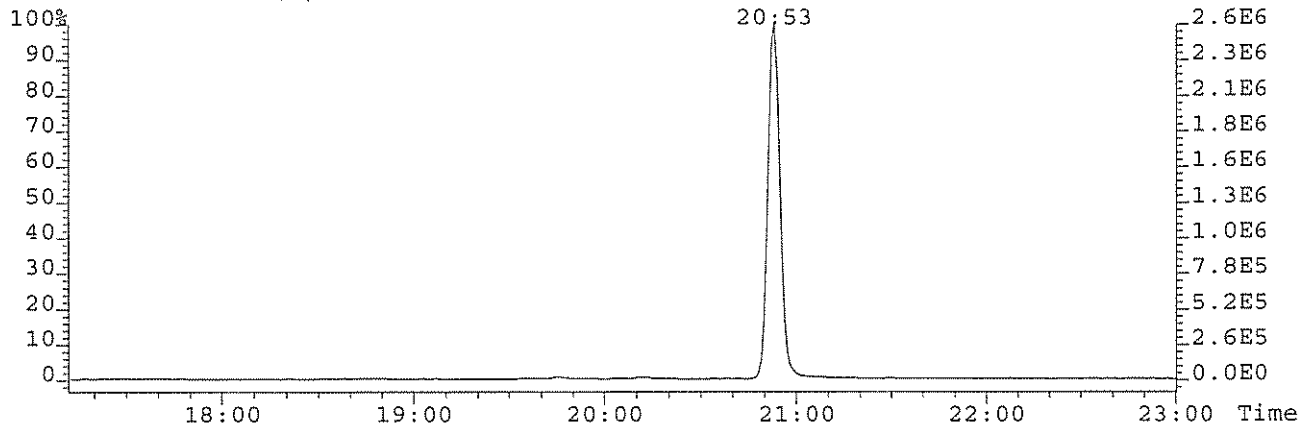
303.9016 S:27 SMO(1,3)



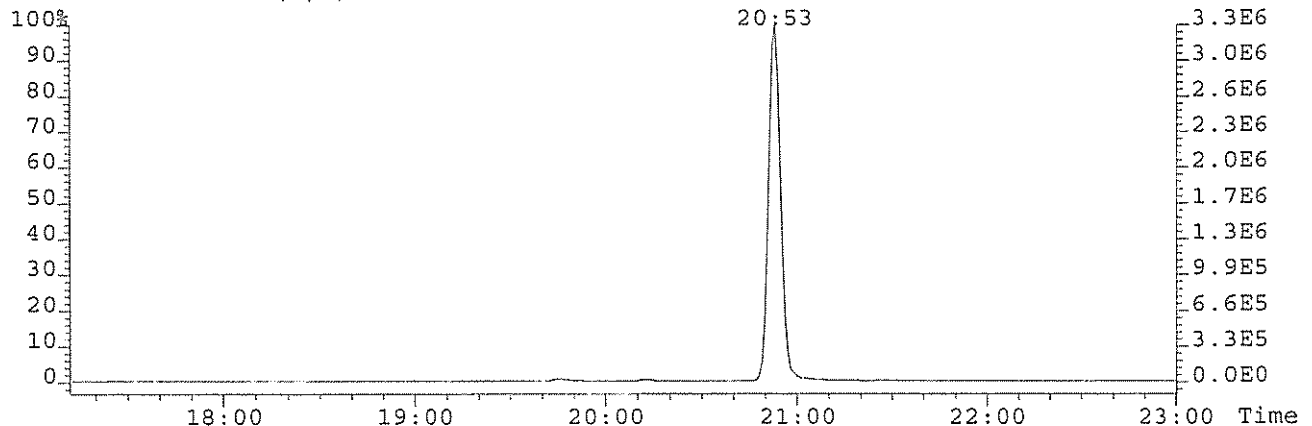
305.8987 S:27 SMO(1,3)



315.9419 S:27 SMO(1,3)



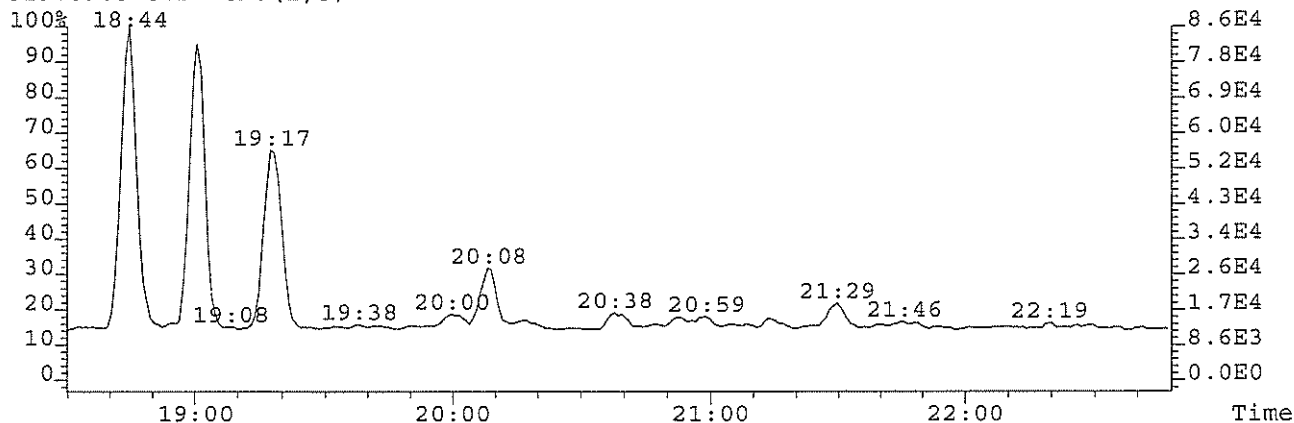
317.9389 S:27 SMO(1,3)



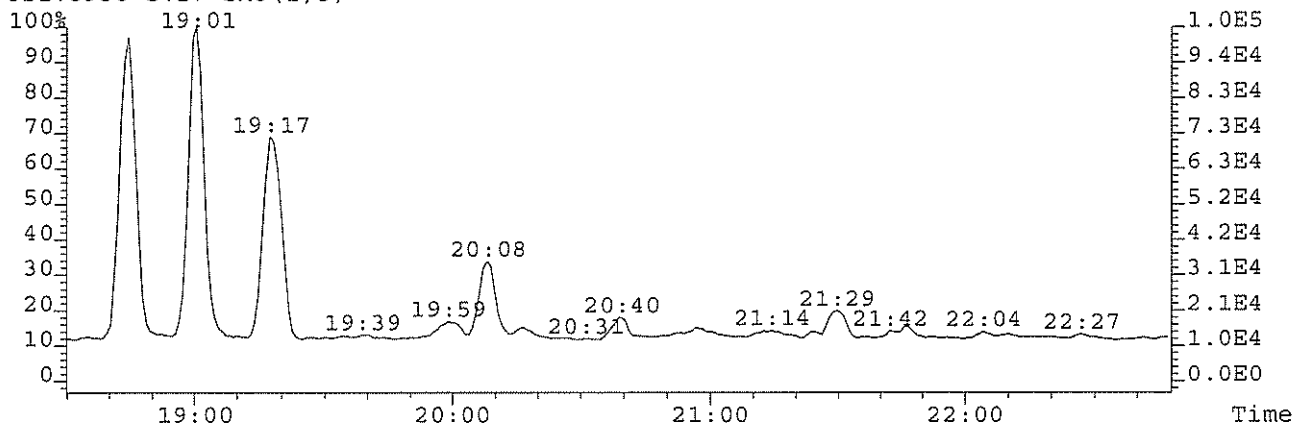
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 12:27:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#27 File Text:BPX-DXN(4-6DXN) Text:XE13 0946 Exp:BPX04

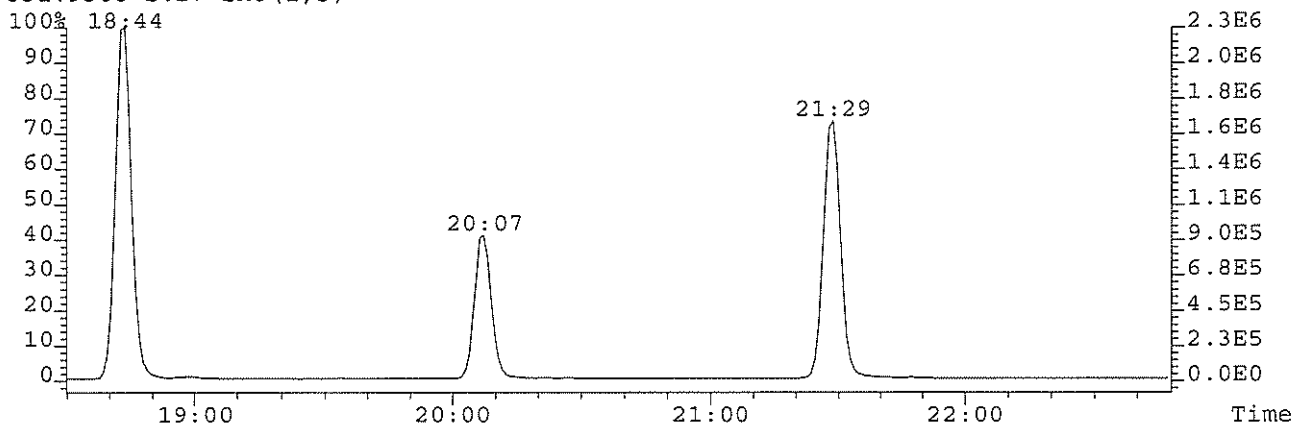
319.8965 S:27 SMO(1,3)



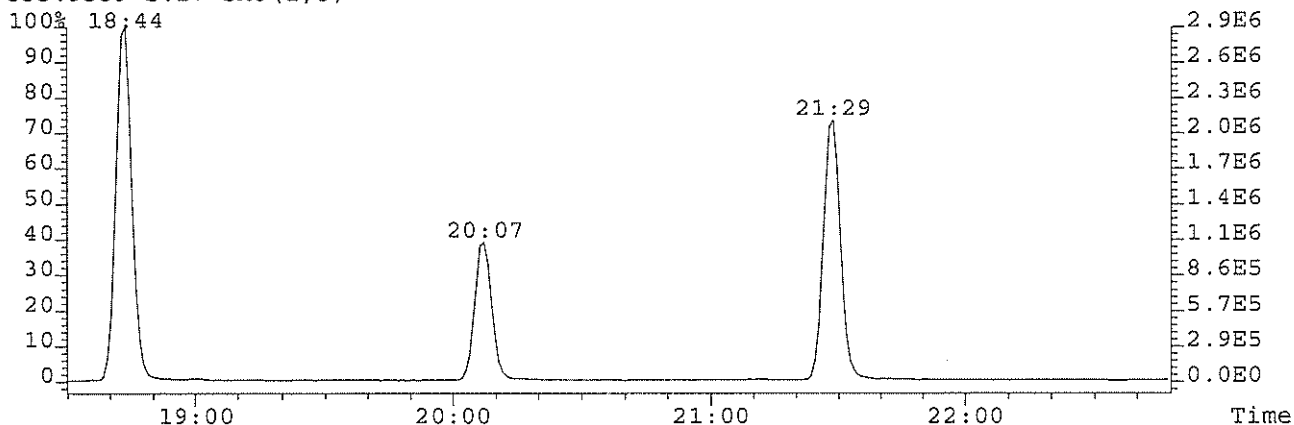
321.8936 S:27 SMO(1,3)



331.9368 S:27 SMO(1,3)



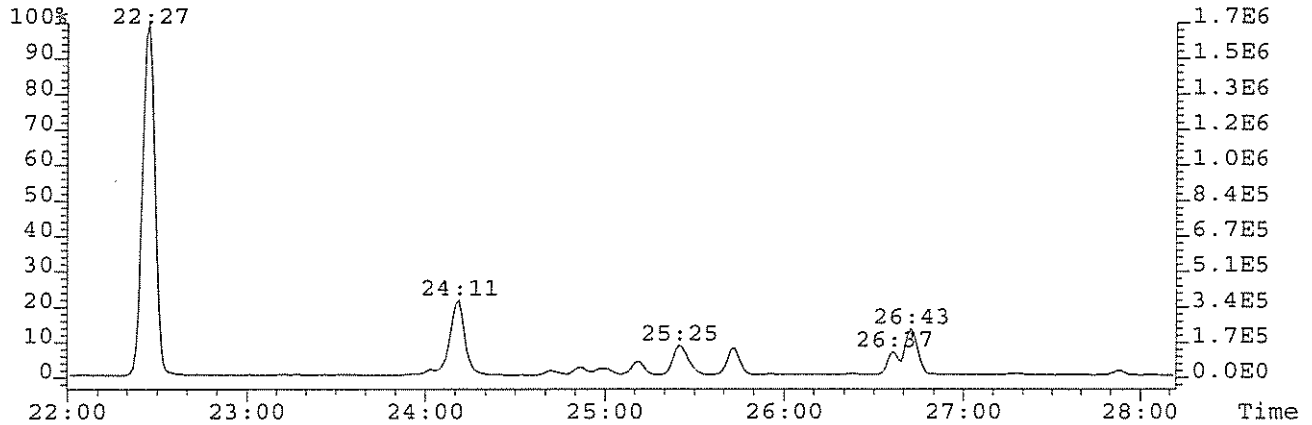
333.9339 S:27 SMO(1,3)



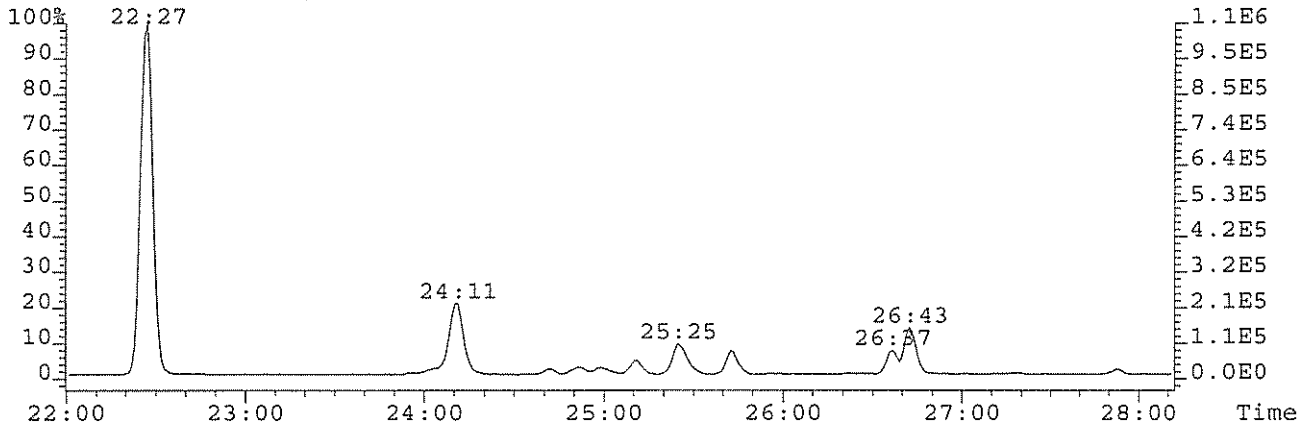
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130712-2 #1-1578 Acq:13-JUL-2013 12:27:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#27 File Text:BPX-DXN(4-6DXN) Text:XE13 0946 Exp:BPX04

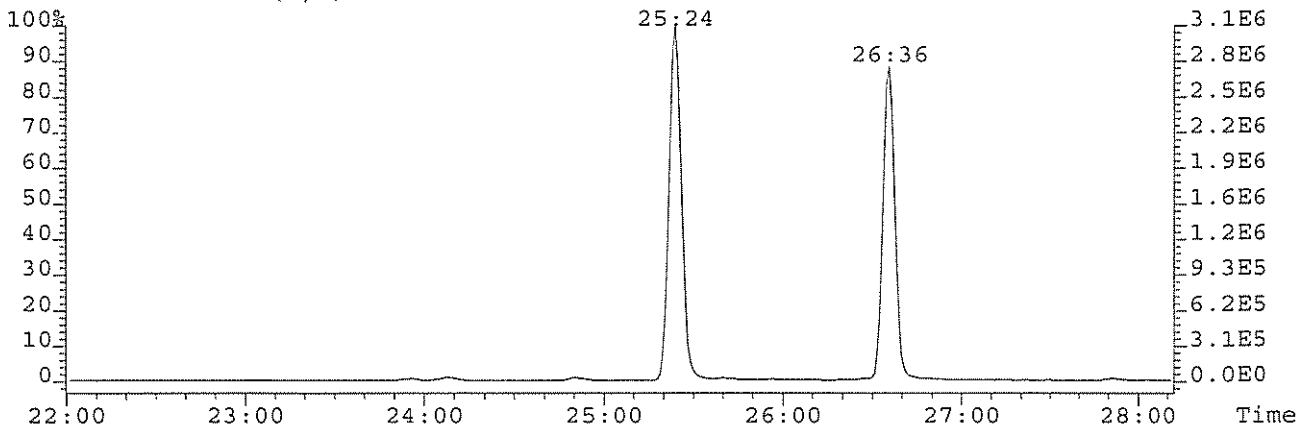
339.8597 S:27 SMO(1,3)



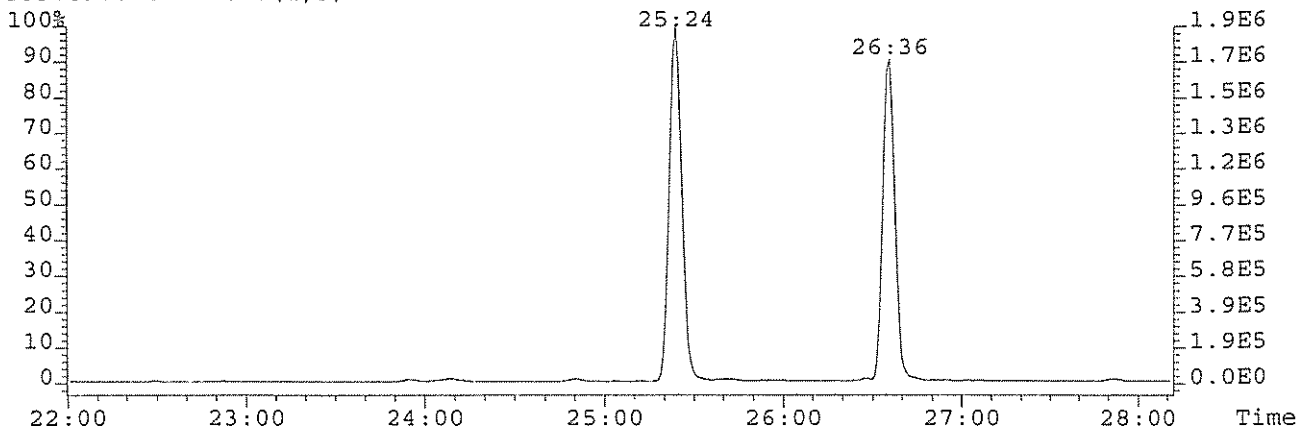
341.8568 S:27 SMO(1,3)



351.9000 S:27 SMO(1,3)

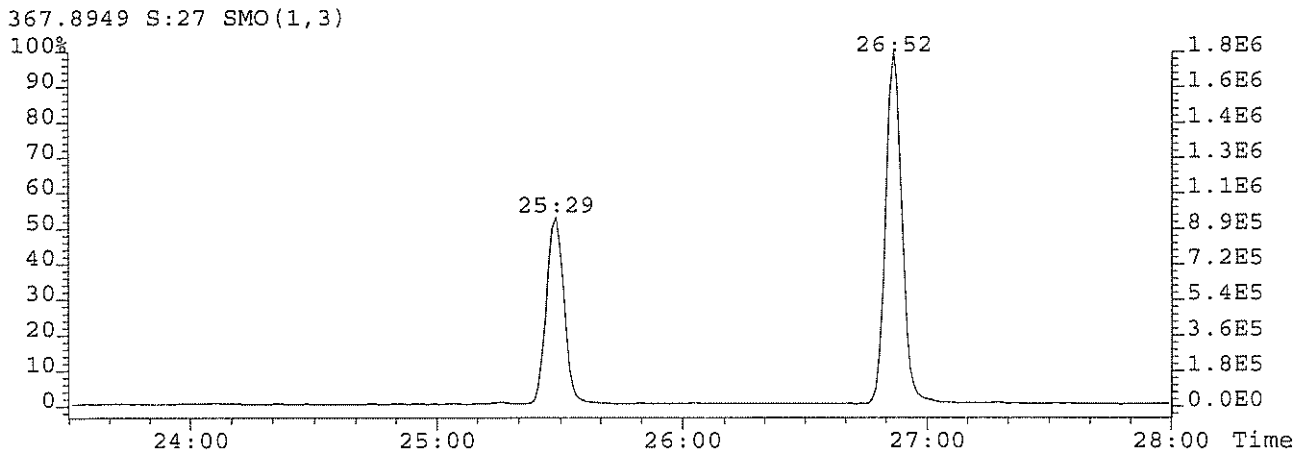
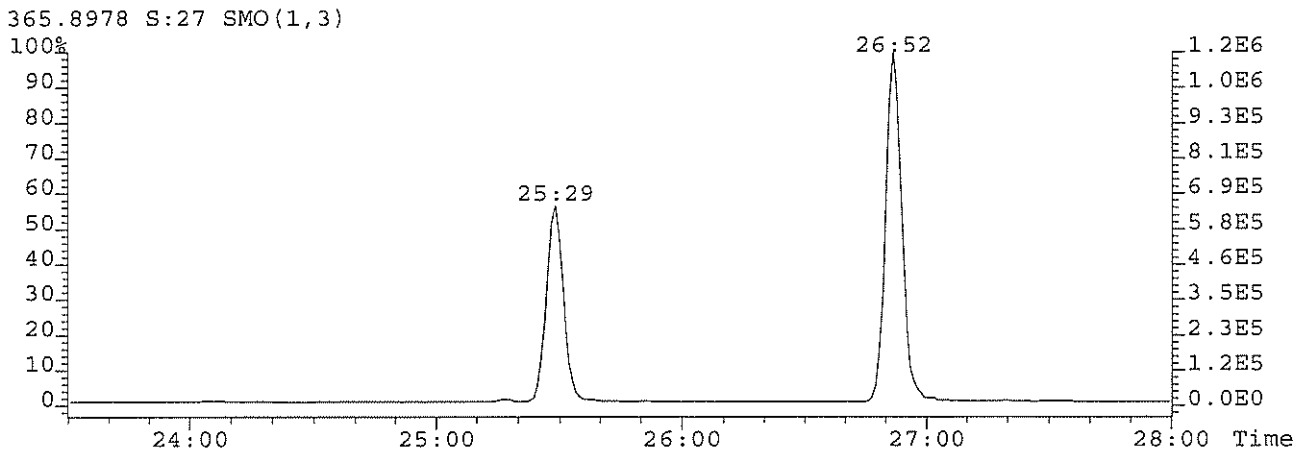
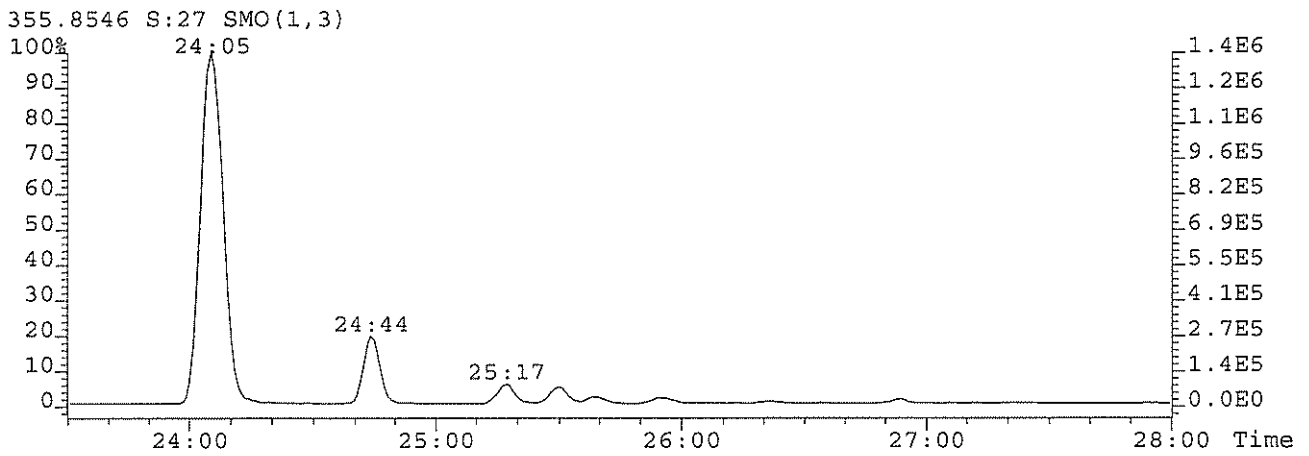
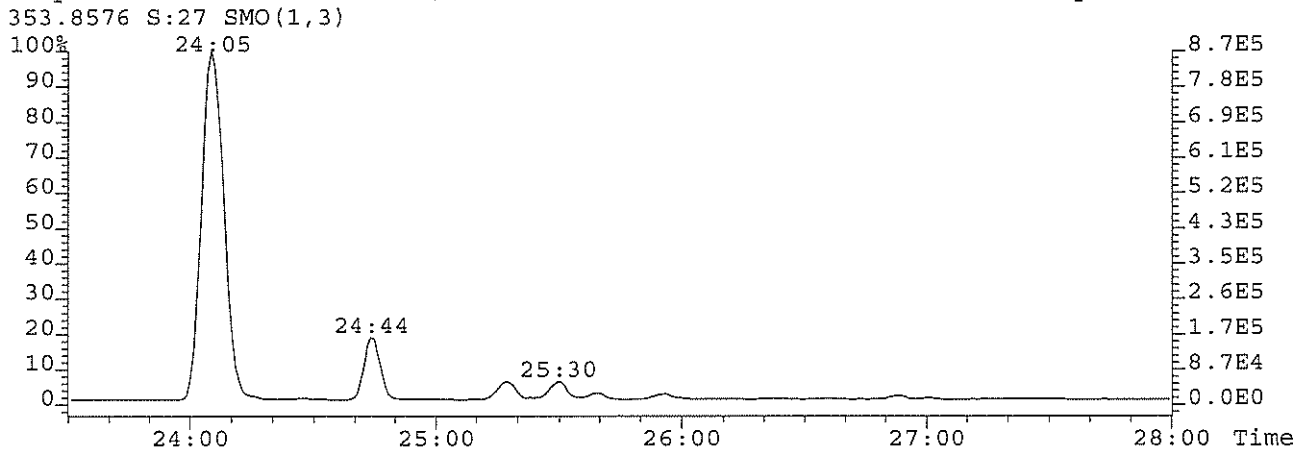


353.8970 S:27 SMO(1,3)



PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 12:27:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#27 File Text:BPX-DXN(4-6DXN) Text:XE13 0946 Exp:BPX04

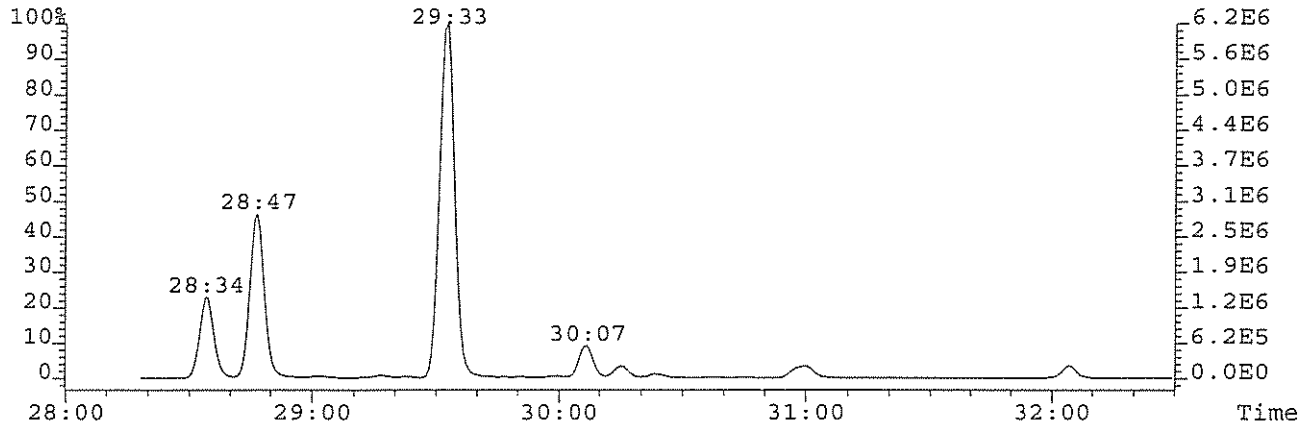


PCDDsクロマトグラム (4)  
(PeCDDs)

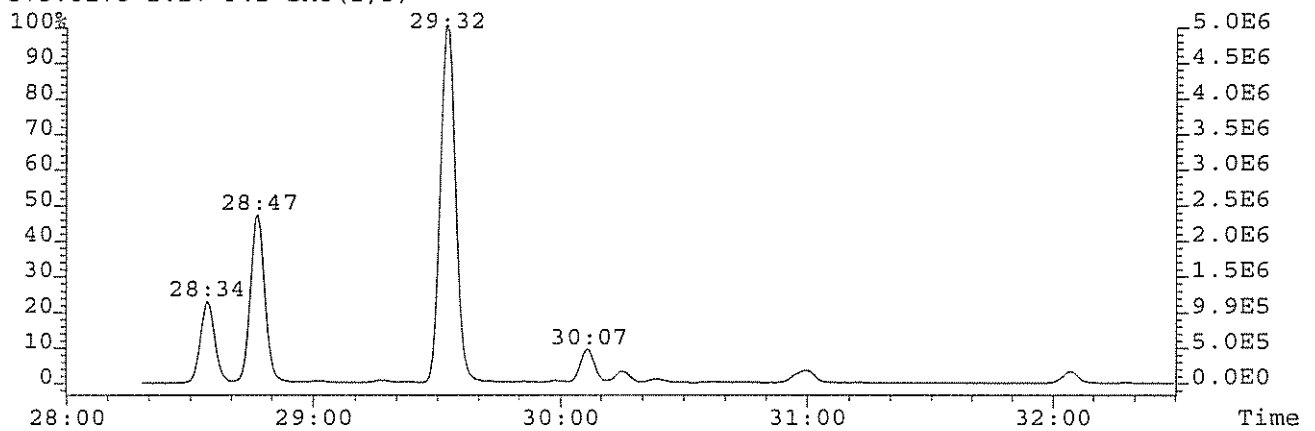


File:130712-2 #1-1116 Acq:13-JUL-2013 12:27:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#27 File Text:BPX-DXN(4-6DXN) Text:XE13 0946 Exp:BPX04

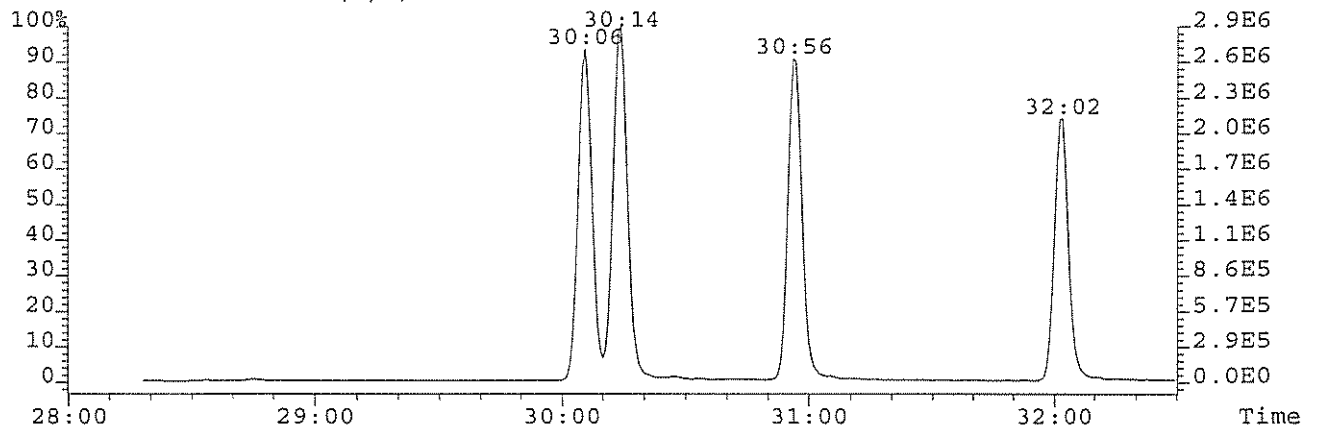
373.8207 S:27 F:2 SMO(1,3)



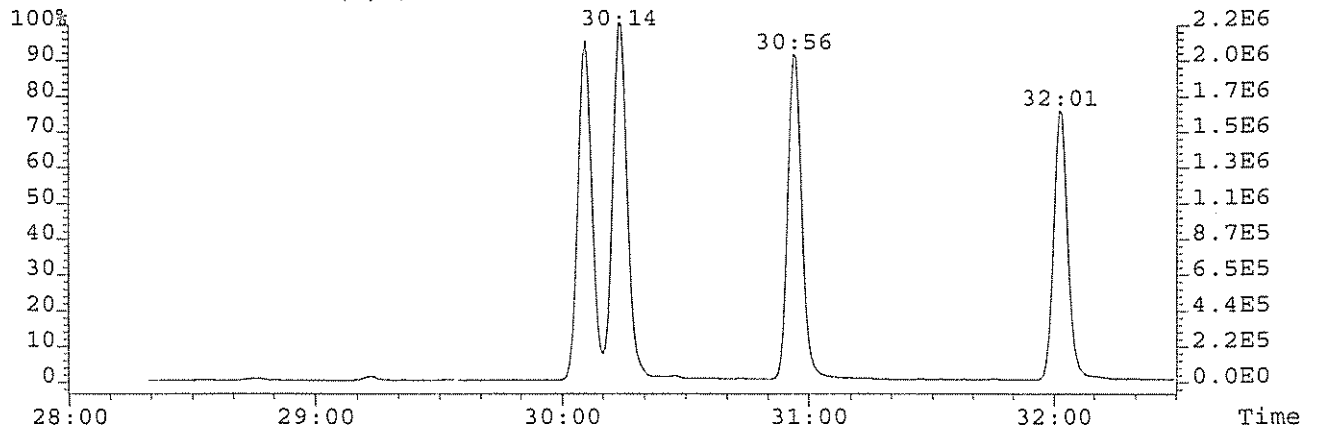
375.8178 S:27 F:2 SMO(1,3)



385.8610 S:27 F:2 SMO(1,3)

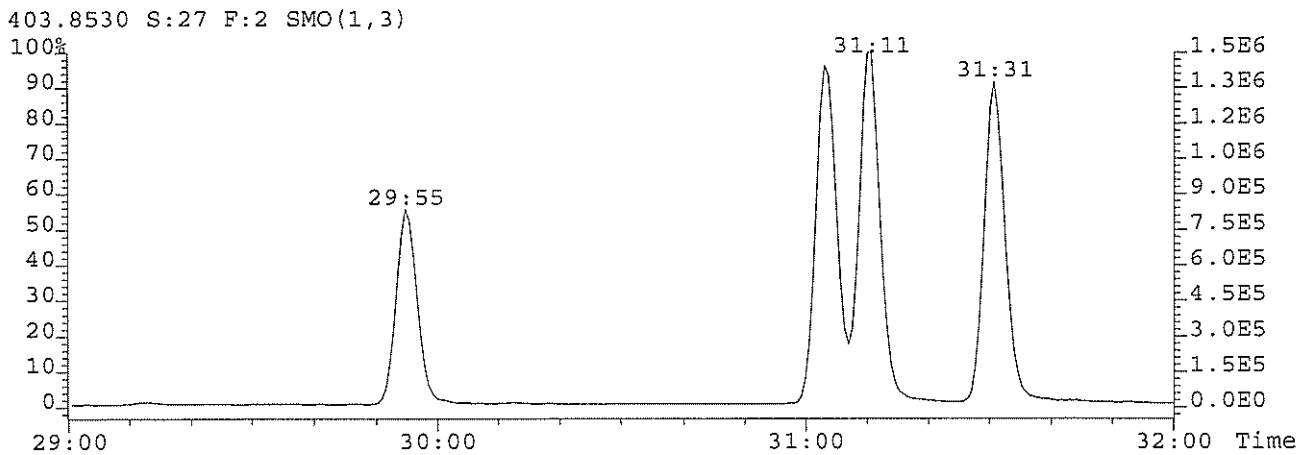
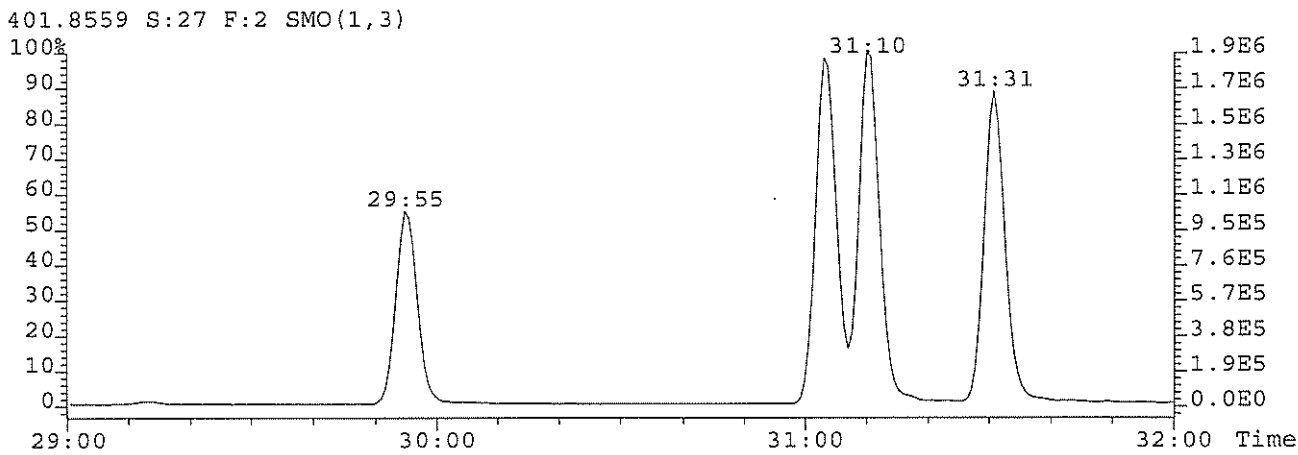
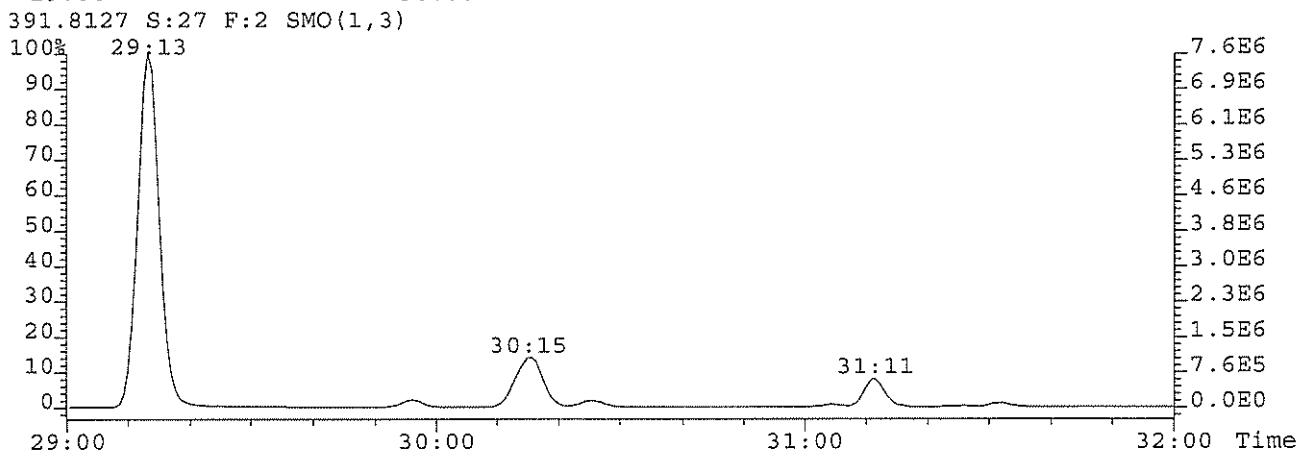
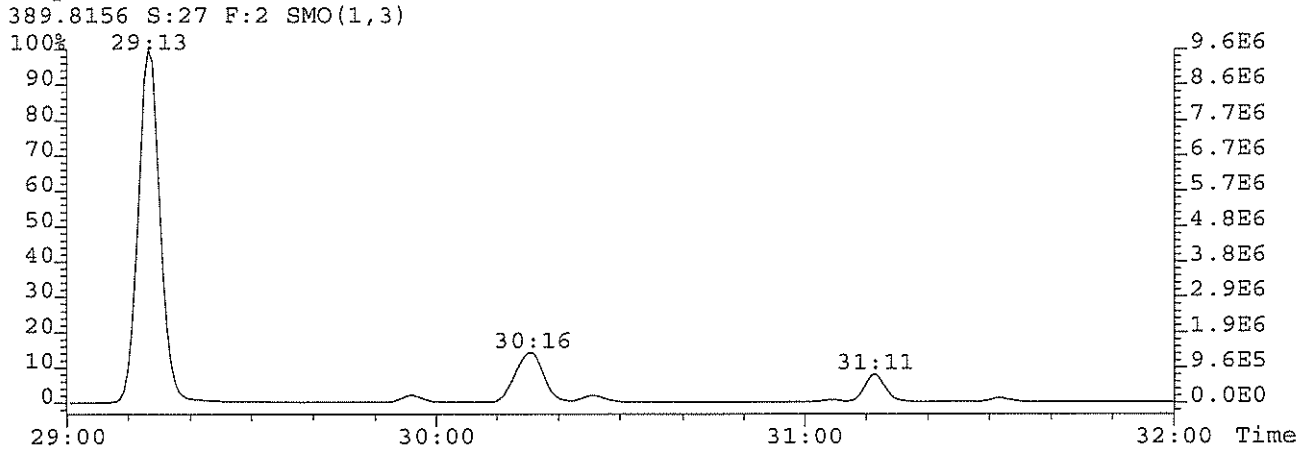


387.8580 S:27 F:2 SMO(1,3)



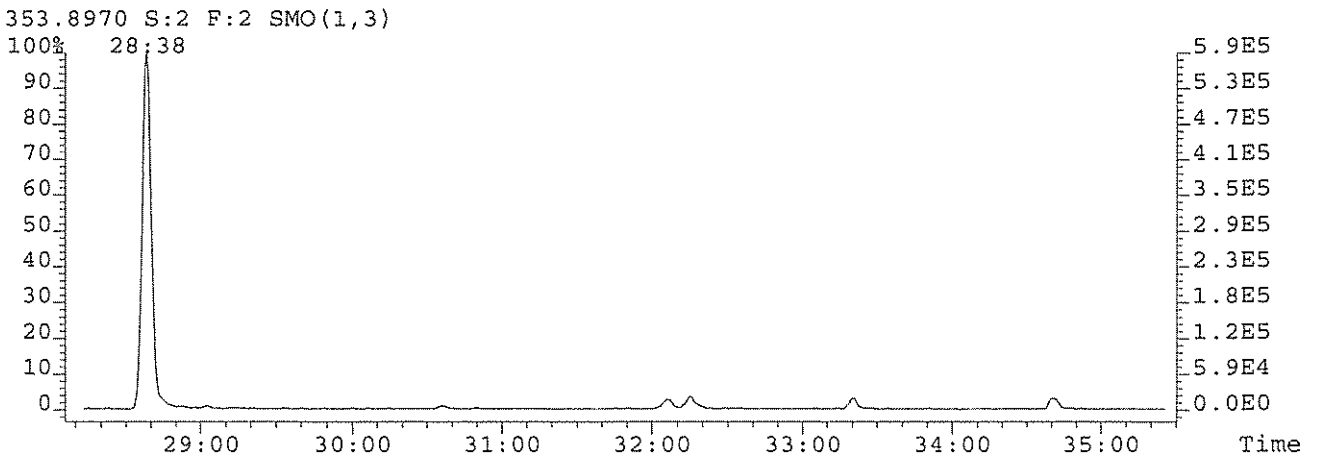
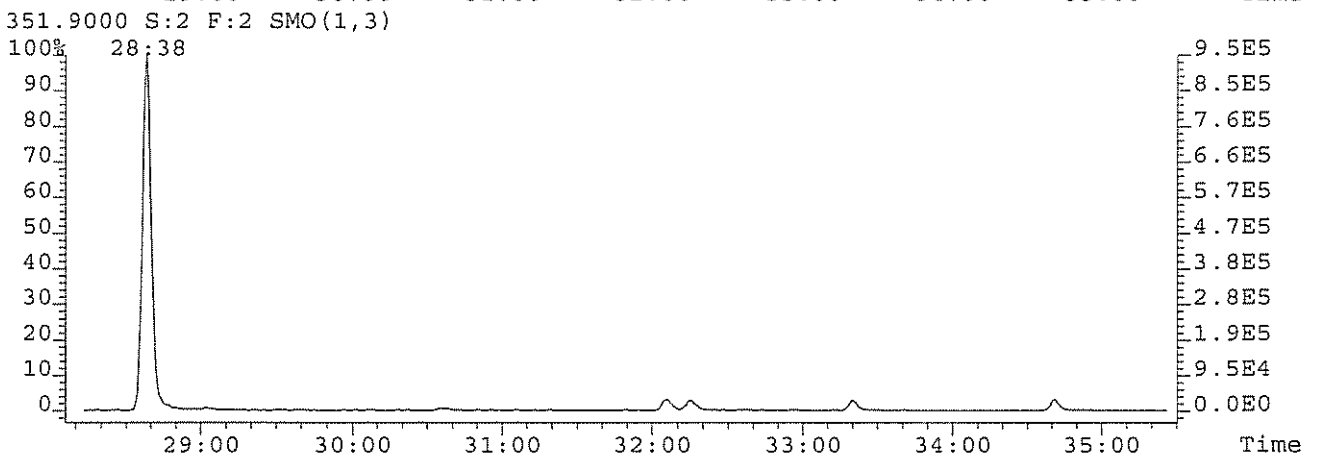
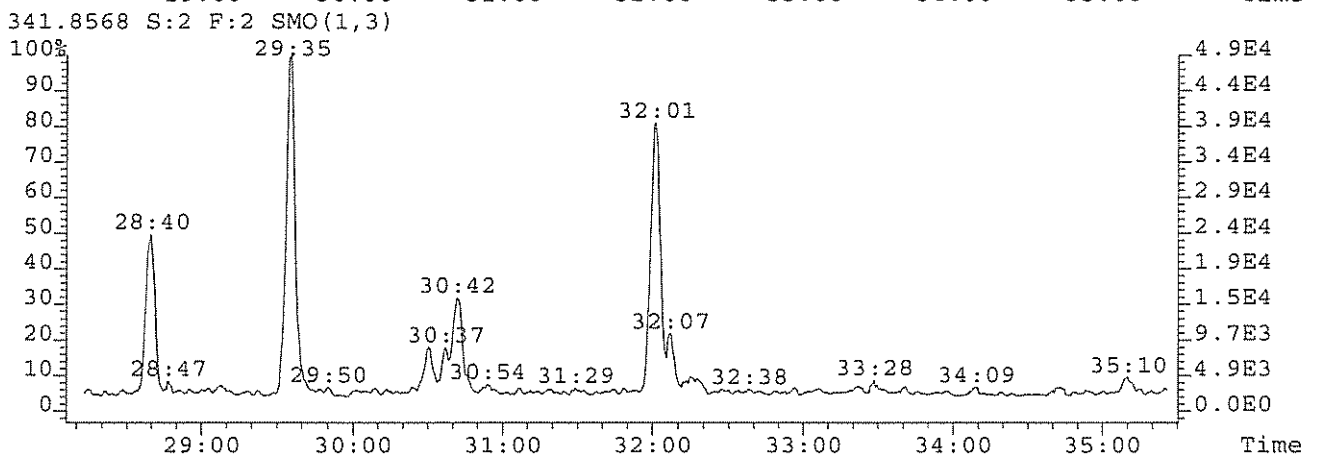
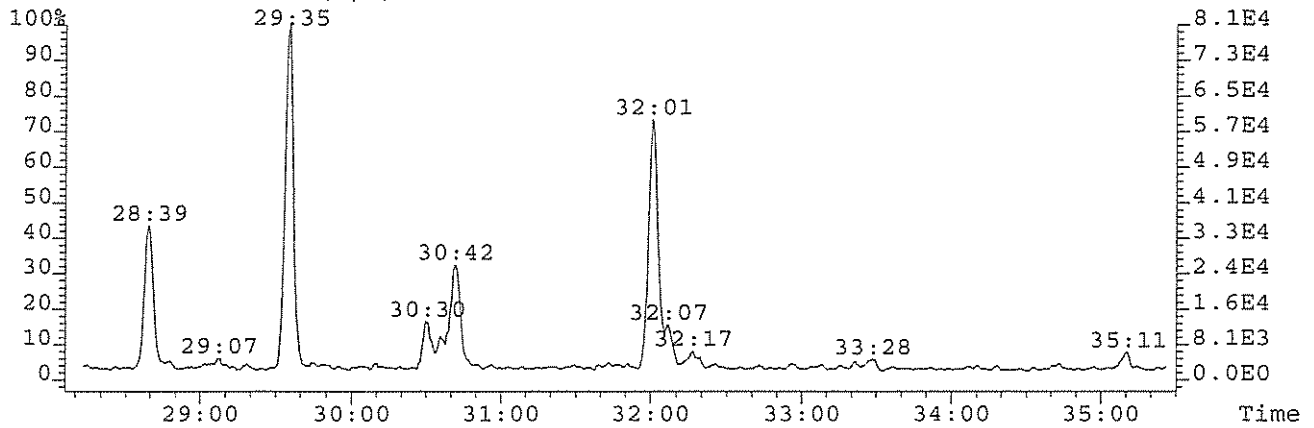
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1116 Acq:13-JUL-2013 12:27:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#27 File Text:BPX-DXN(4-6DXN) Text:XE13 0946 Exp:BPX04



PCDDsクロマトグラム (6)  
(HxCDDs)

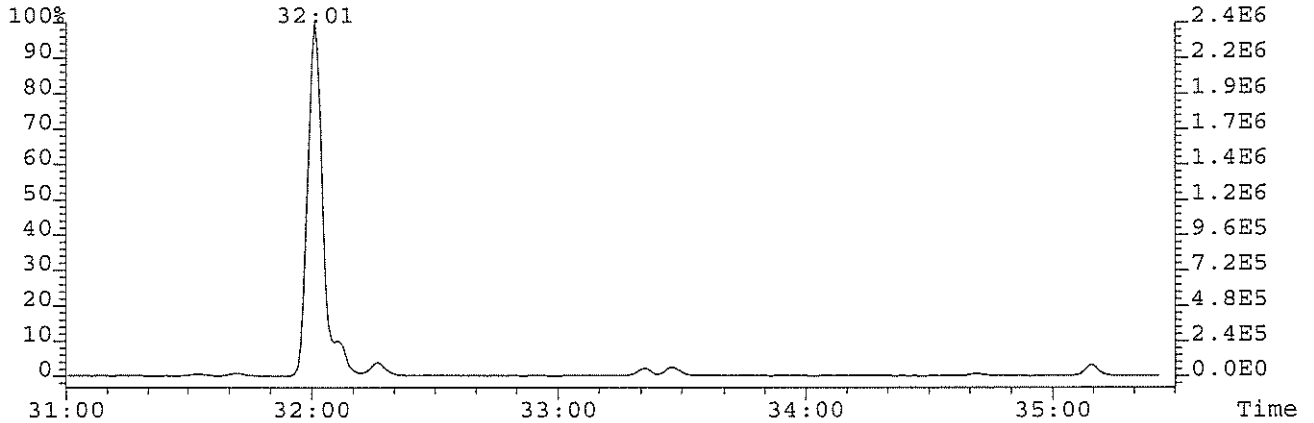
File:130716-2 #1-648 Acq:16-JUL-2013 15:19:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:XE13 0946 3 Exp:RH-PD22  
339.8597 S:2 F:2 SMO(1,3)



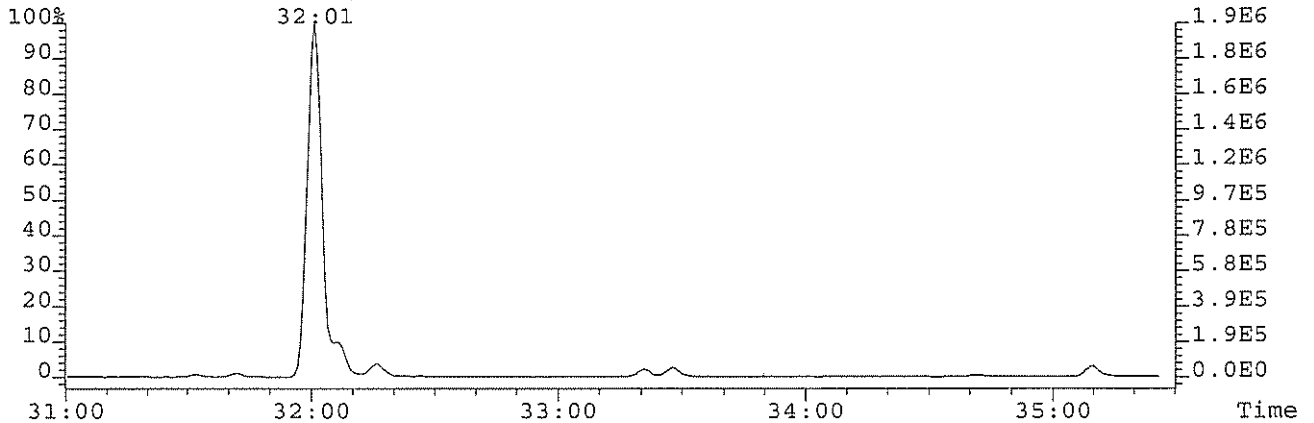
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130716-2 #1-648 Acq:16-JUL-2013 15:19:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:XE13 0946 3 Exp:RH-PD22

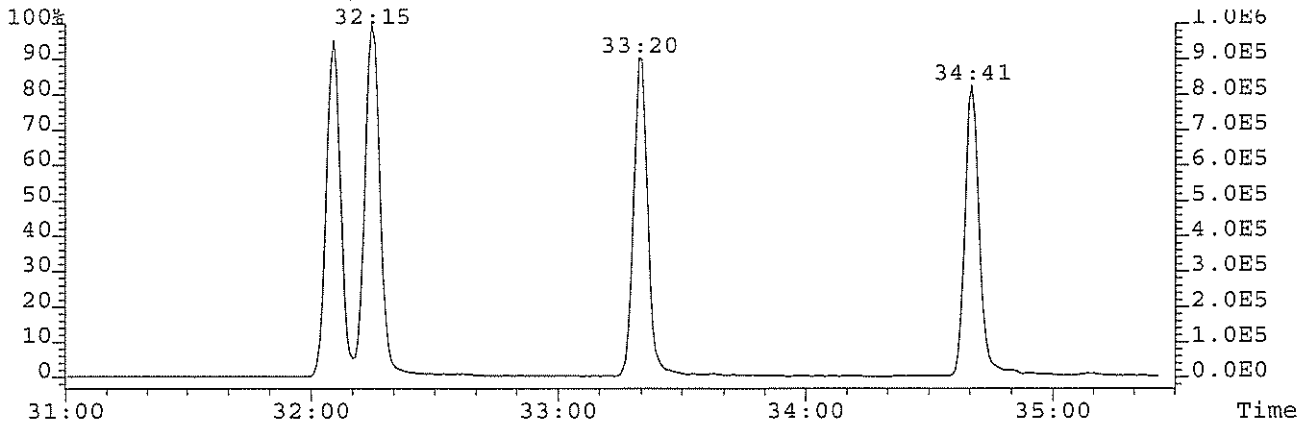
373.8207 S:2 F:2 SMO(1,3)



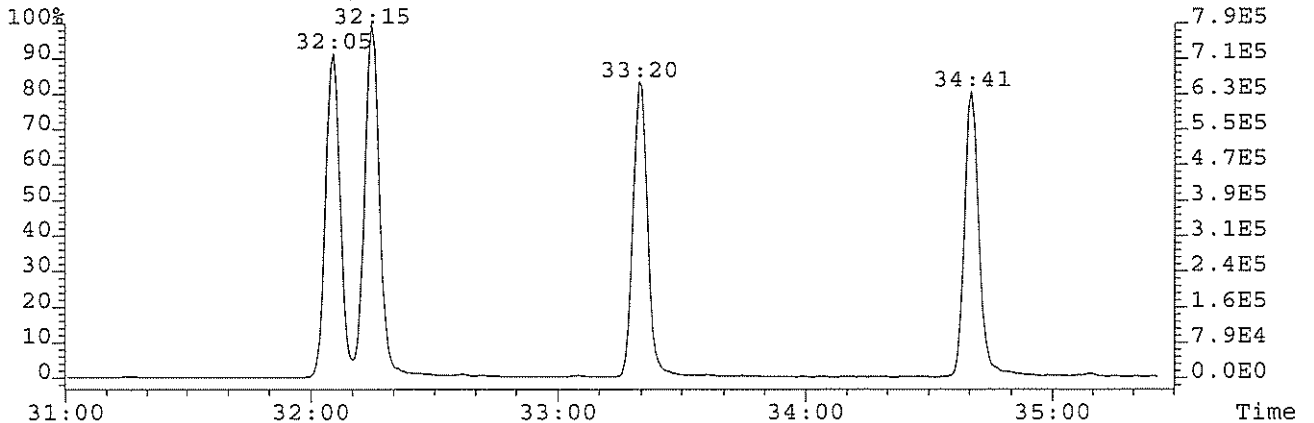
375.8178 S:2 F:2 SMO(1,3)



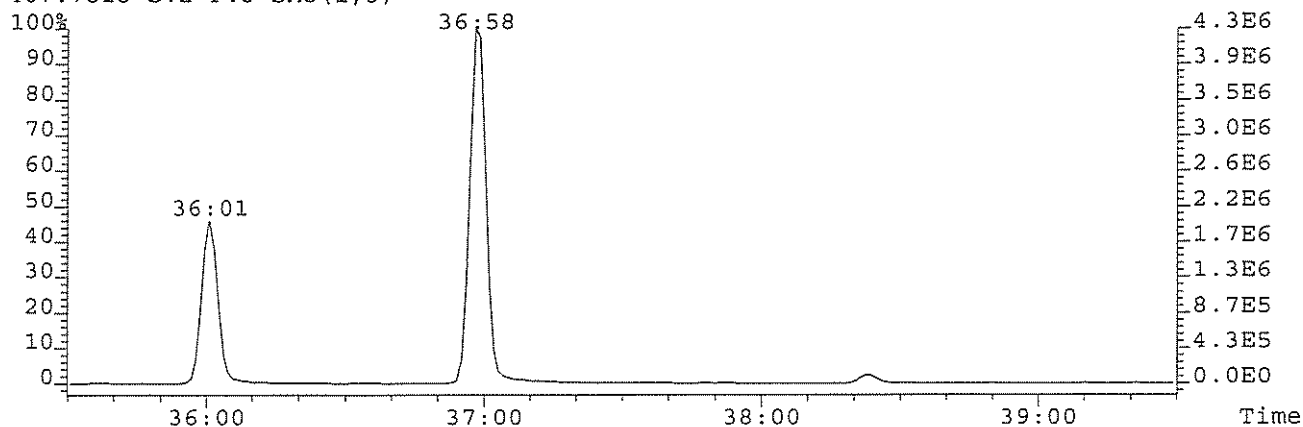
385.8610 S:2 F:2 SMO(1,3)



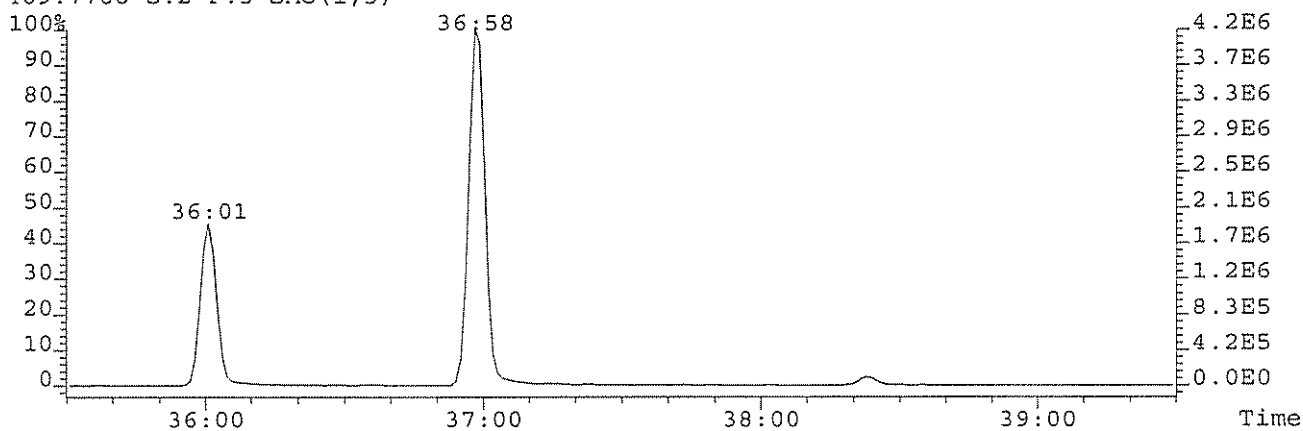
387.8580 S:2 F:2 SMO(1,3)



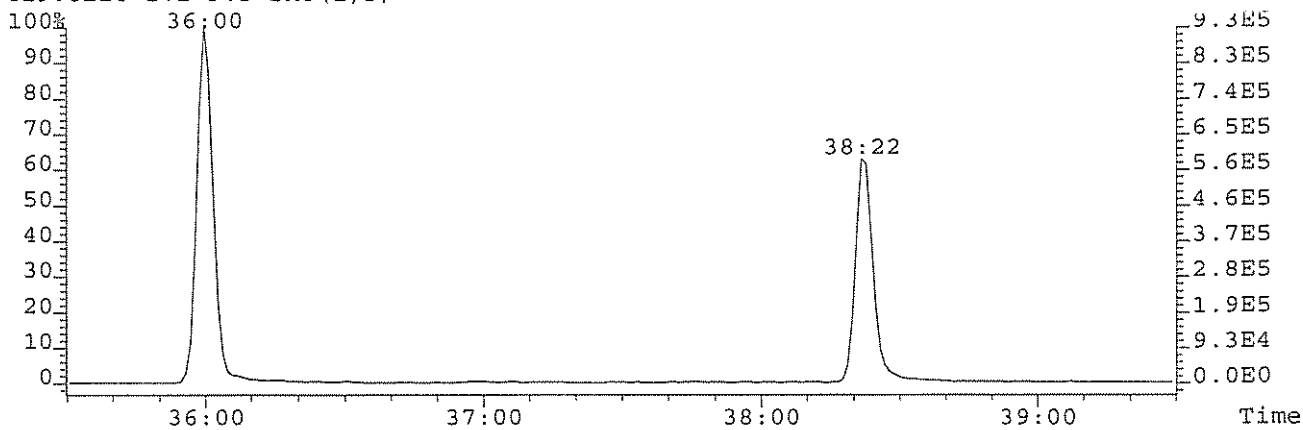
File:130716-2 #1-562 Acq:16-JUL-2013 15:19:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:XE13 0946 3 Exp:RH-PD22  
407.7818 S:2 F:3 SMO(1,3)



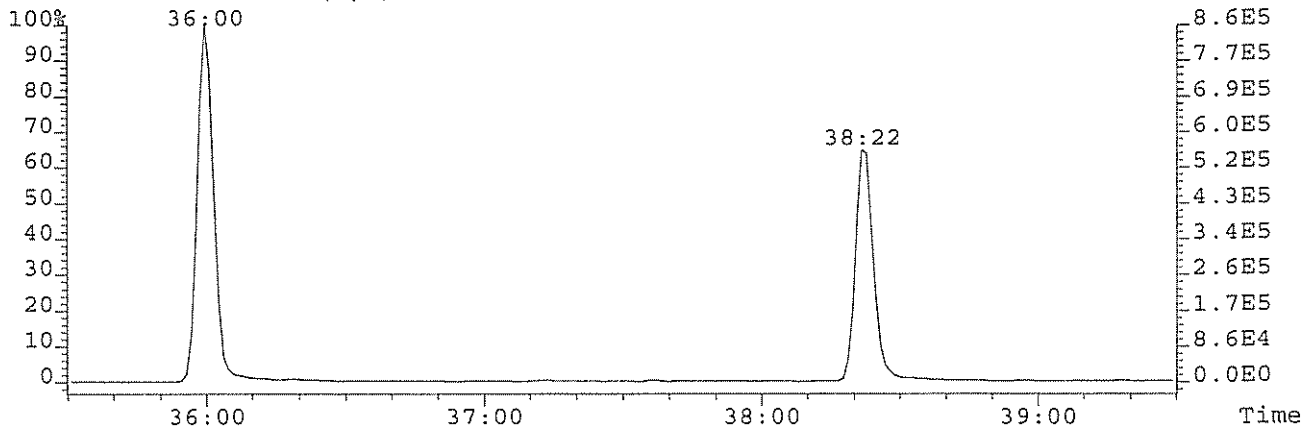
409.7788 S:2 F:3 SMO(1,3)



419.8220 S:2 F:3 SMO(1,3)



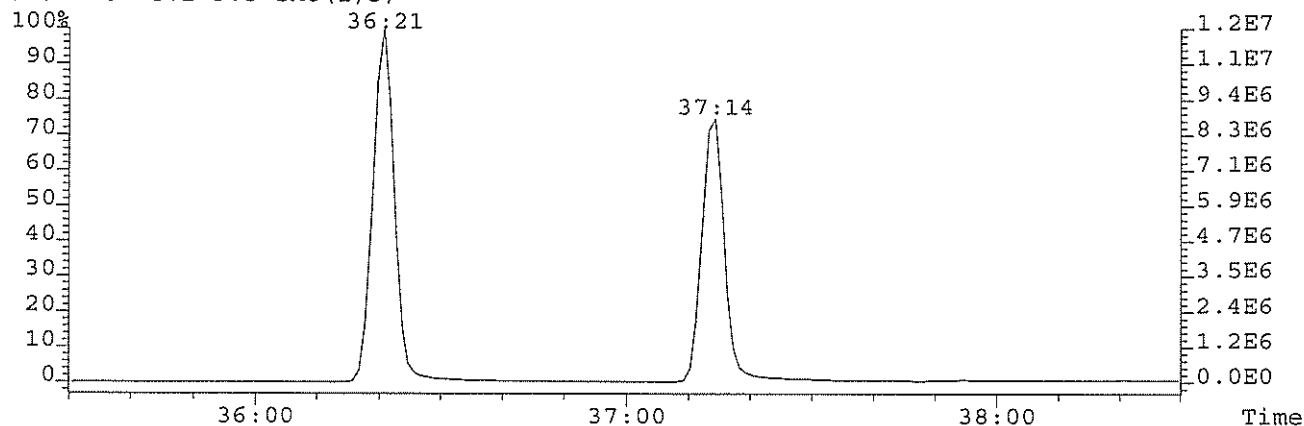
421.8191 S:2 F:3 SMO(1,3)



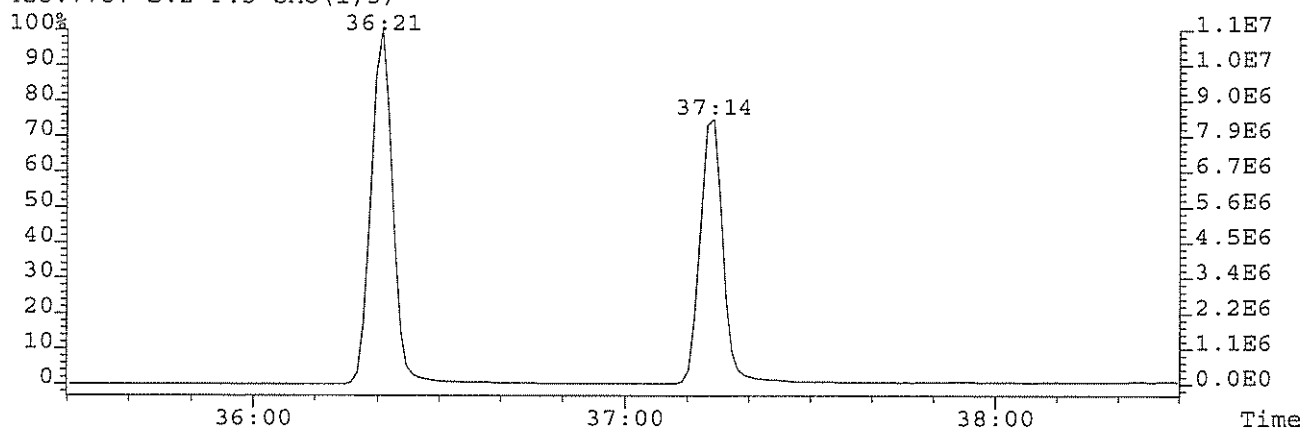
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130716-2 #1-562 Acq:16-JUL-2013 15:19:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:XE13 0946 3 Exp:RH-PD22

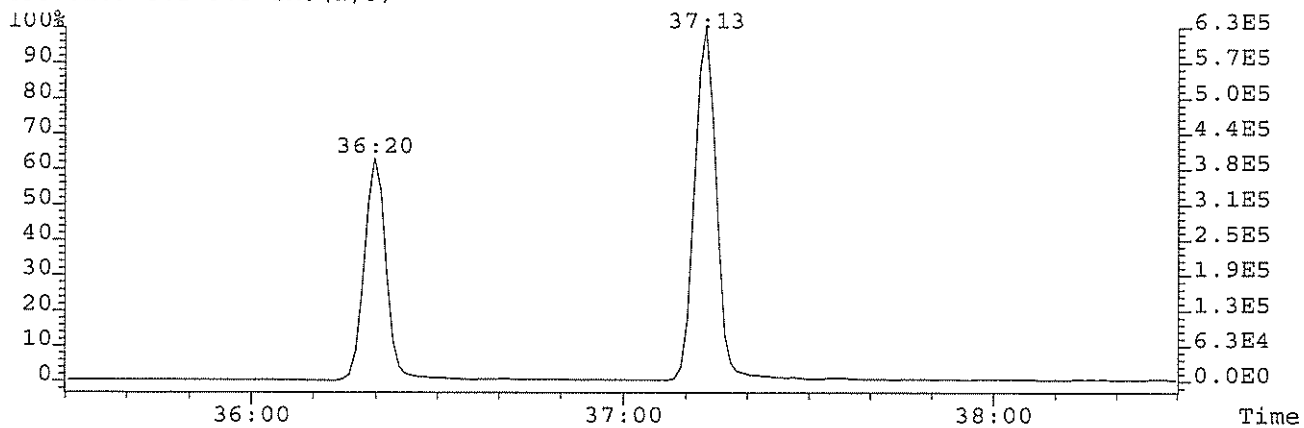
423.7767 S:2 F:3 SMO(1,3)



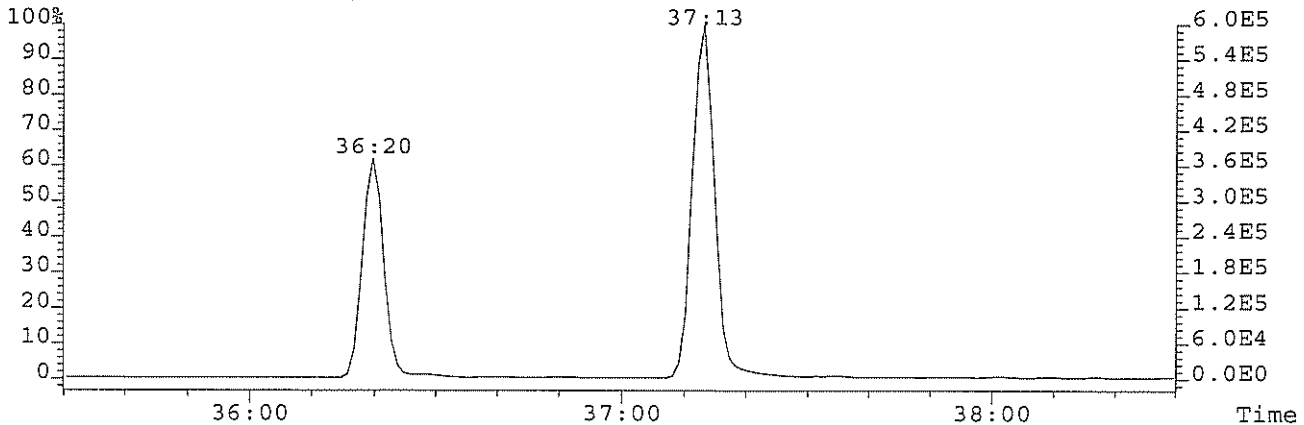
425.7737 S:2 F:3 SMO(1,3)



435.8169 S:2 F:3 SMO(1,3)

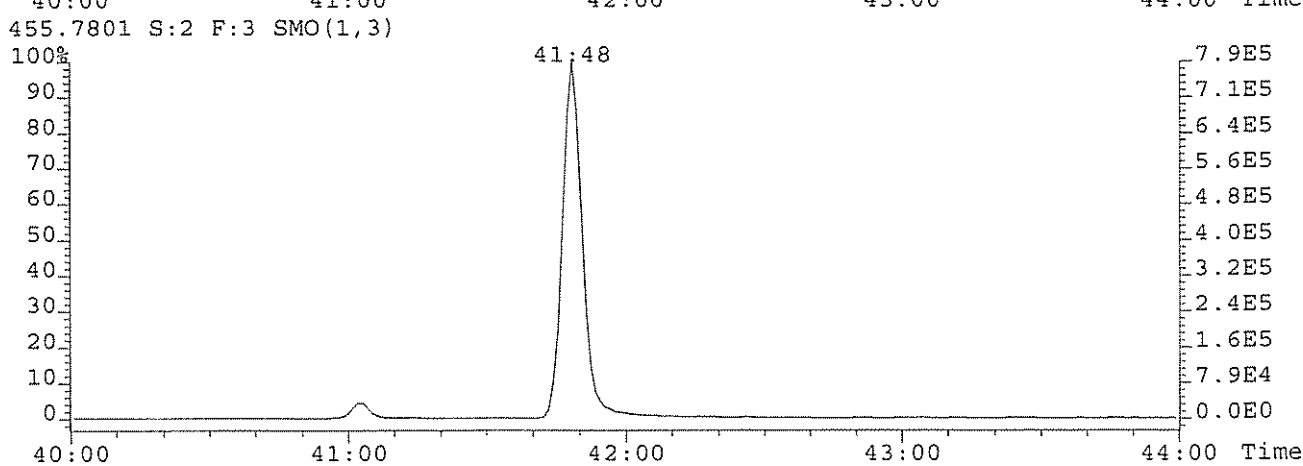
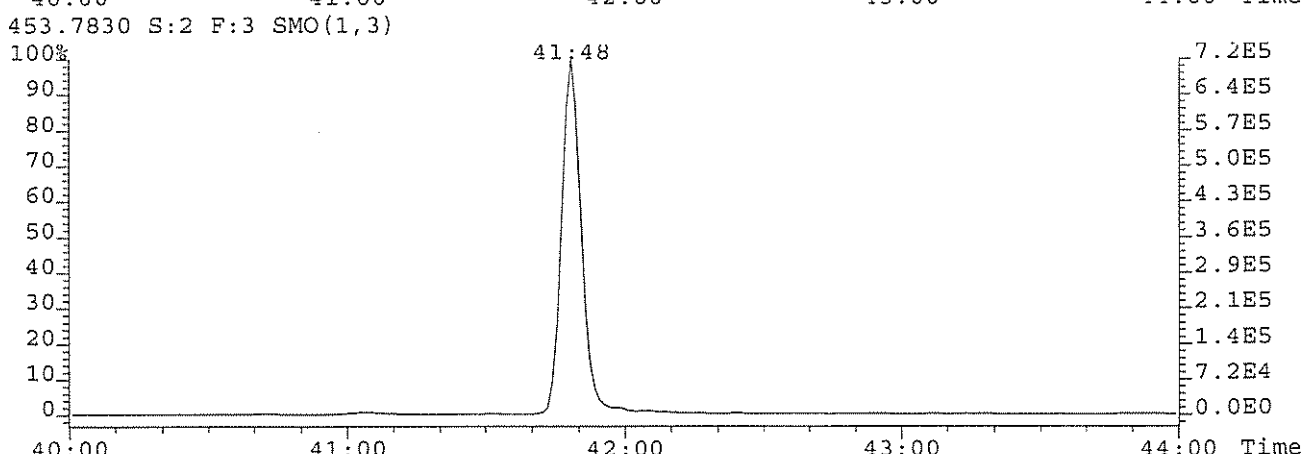
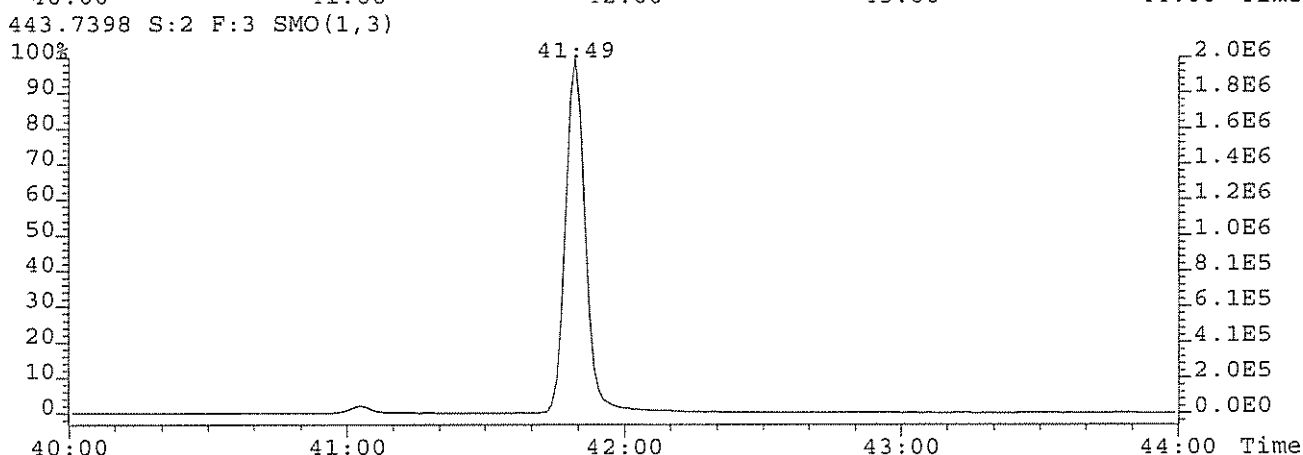
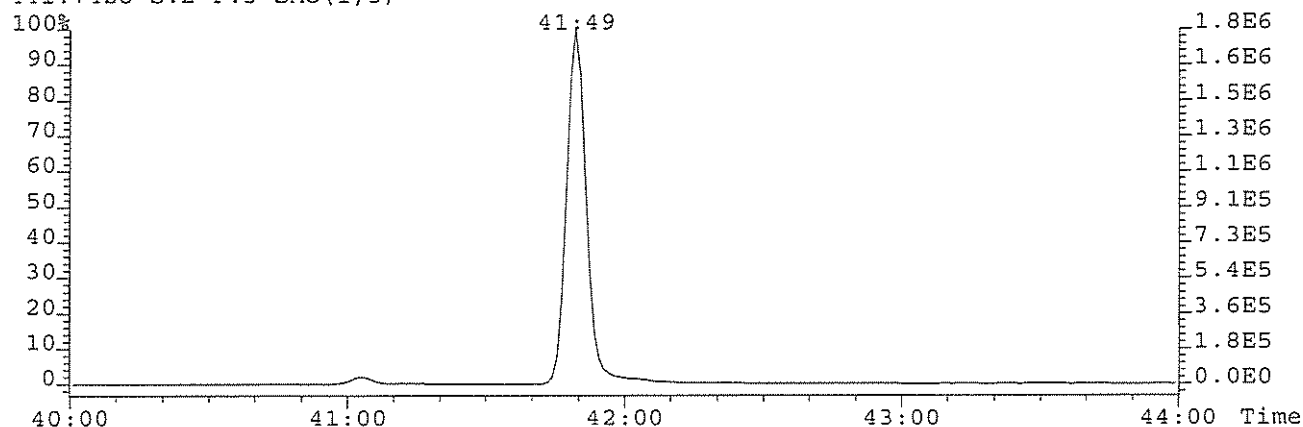


437.8140 S:2 F:3 SMO(1,3)



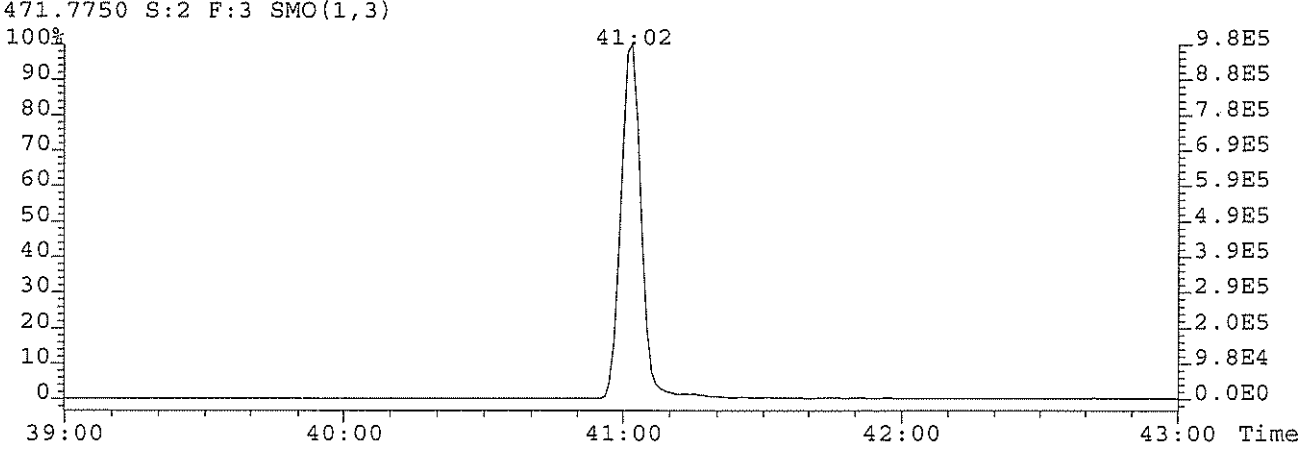
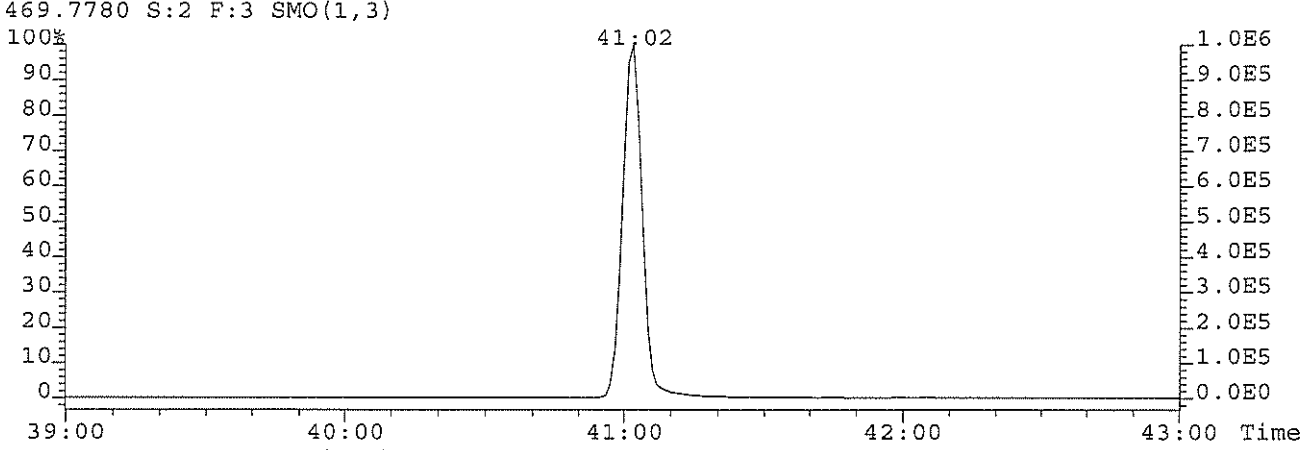
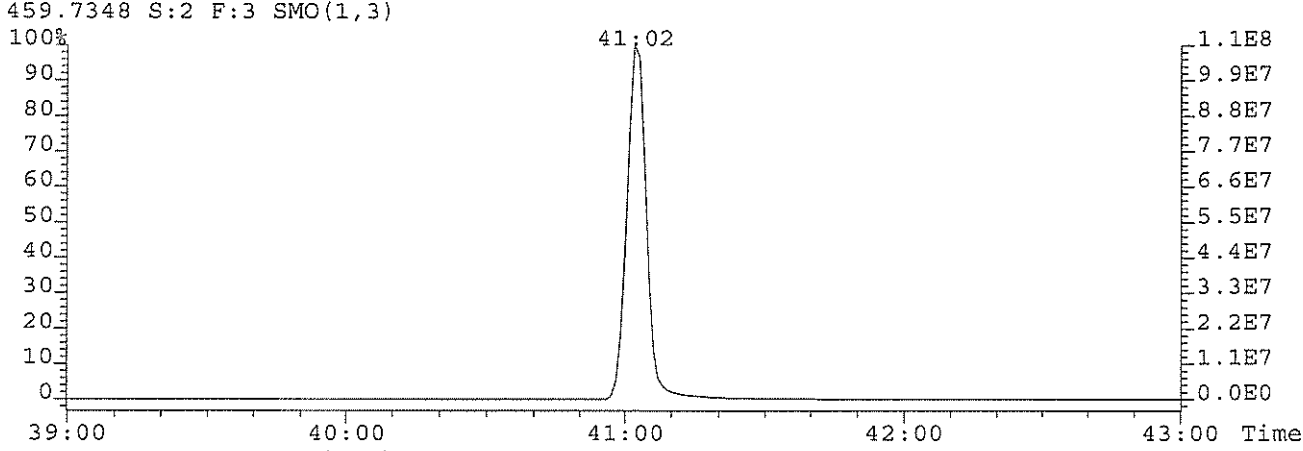
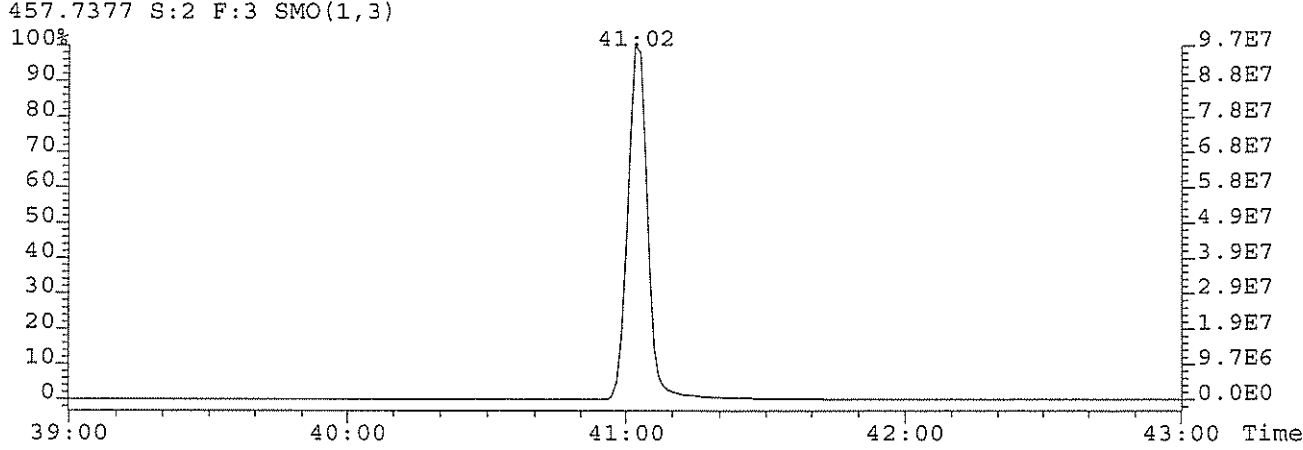
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130716-2 #1-562 Acq:16-JUL-2013 15:19:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:XE13 0946 3 Exp:RH-PD22  
441.7428 S:2 F:3 SMO(1,3)



PCDFsクロマトグラム (11)  
(OCDF)

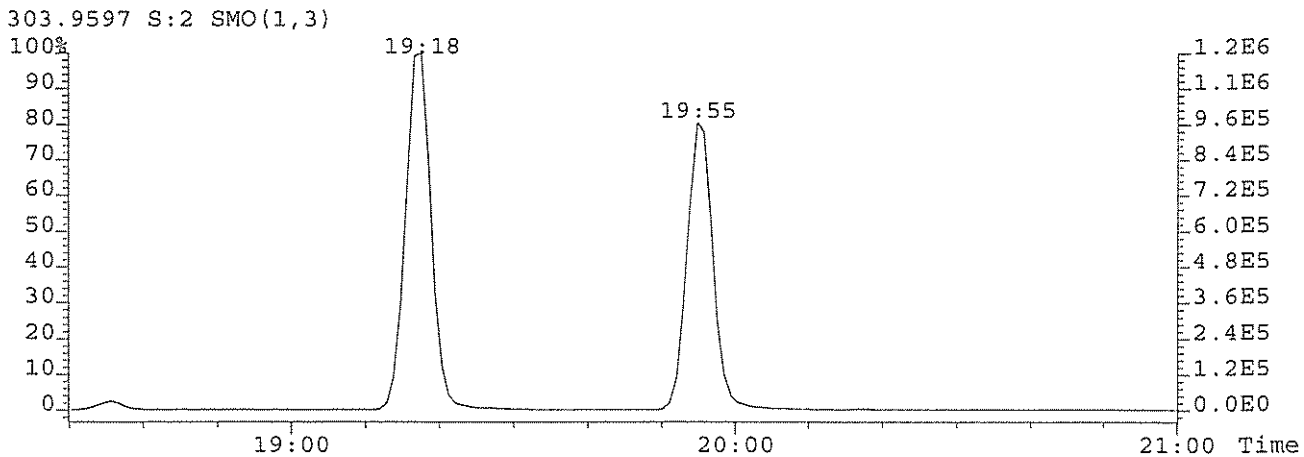
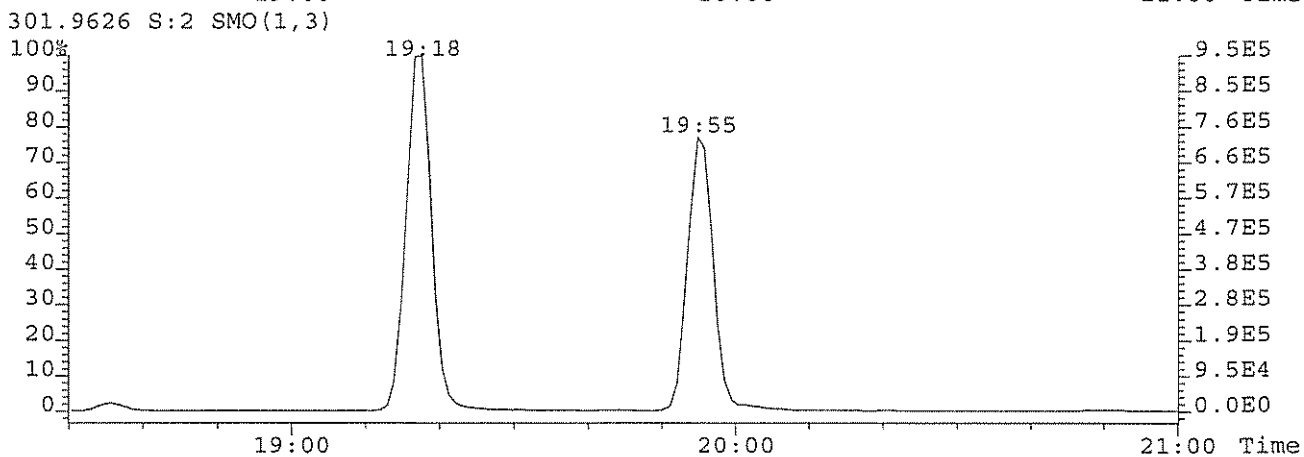
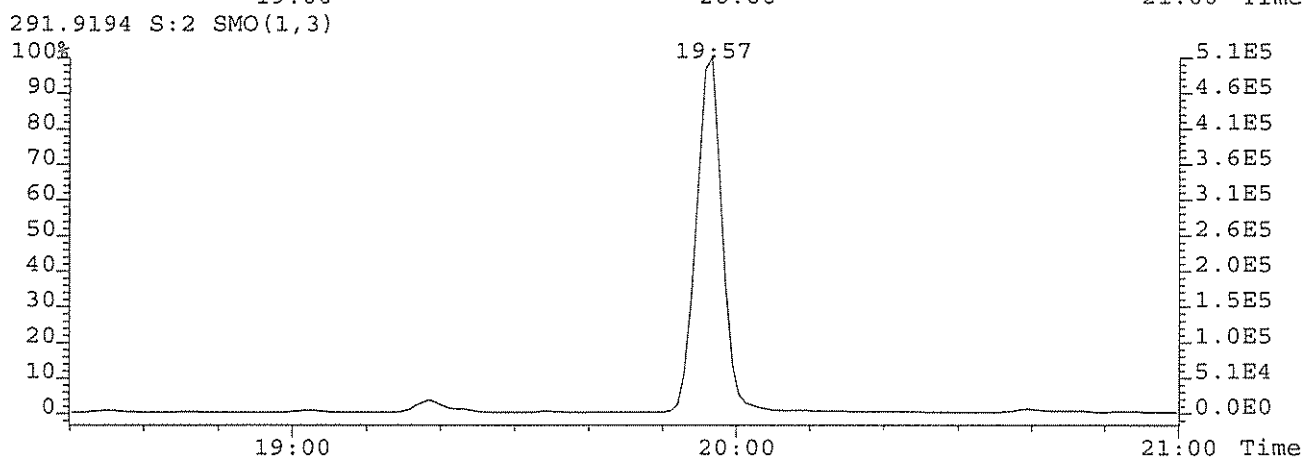
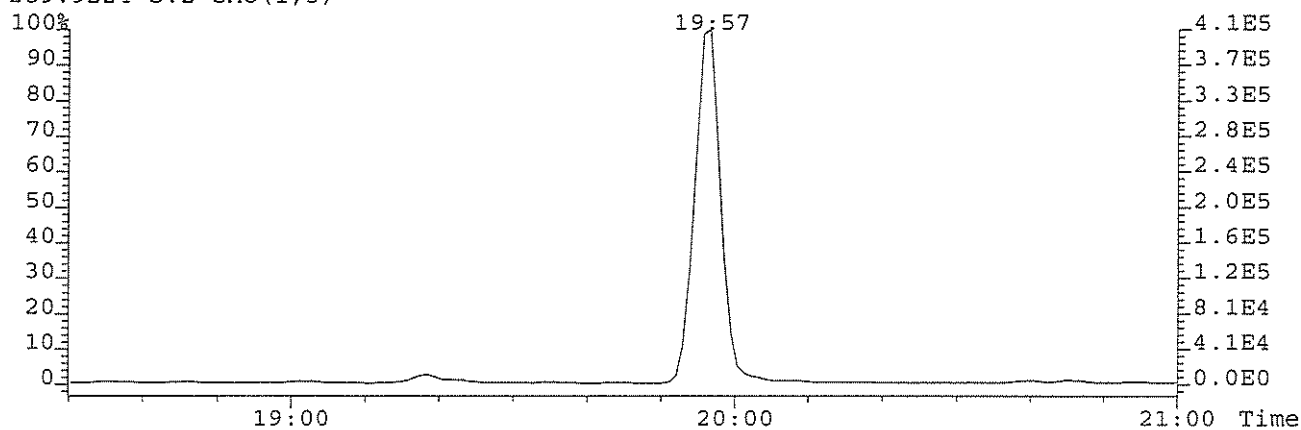
File:130716-2 #1-562 Acq:16-JUL-2013 15:19:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:XE13 0946 3 Exp:RH-PD22



PCDDsクロマトグラム (12)  
(OCDD)



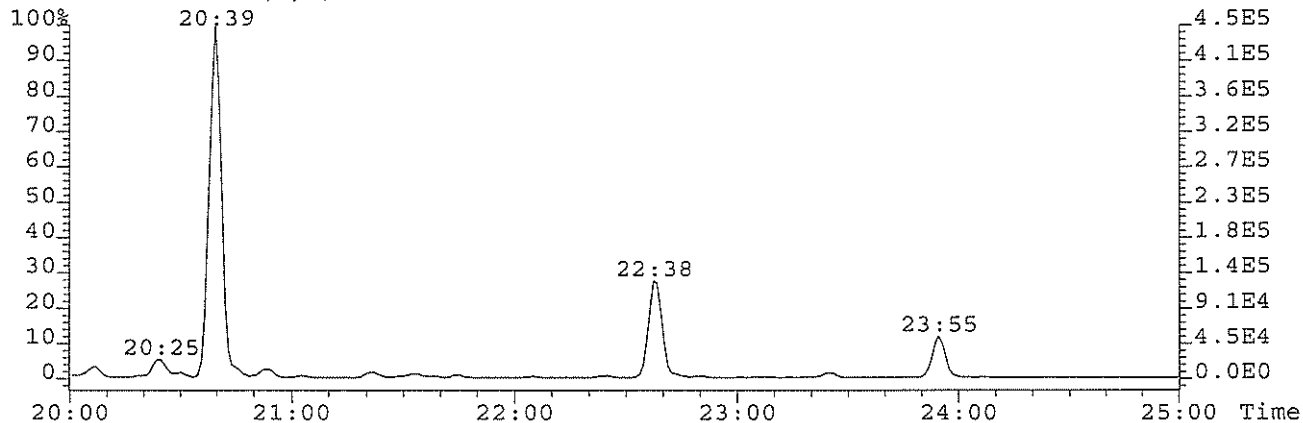
File:130716-2 #1-1430 Acq:16-JUL-2013 15:19:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:XE13 0946 3 Exp:RH-PD22  
289.9224 S:2 SMO(1,3)



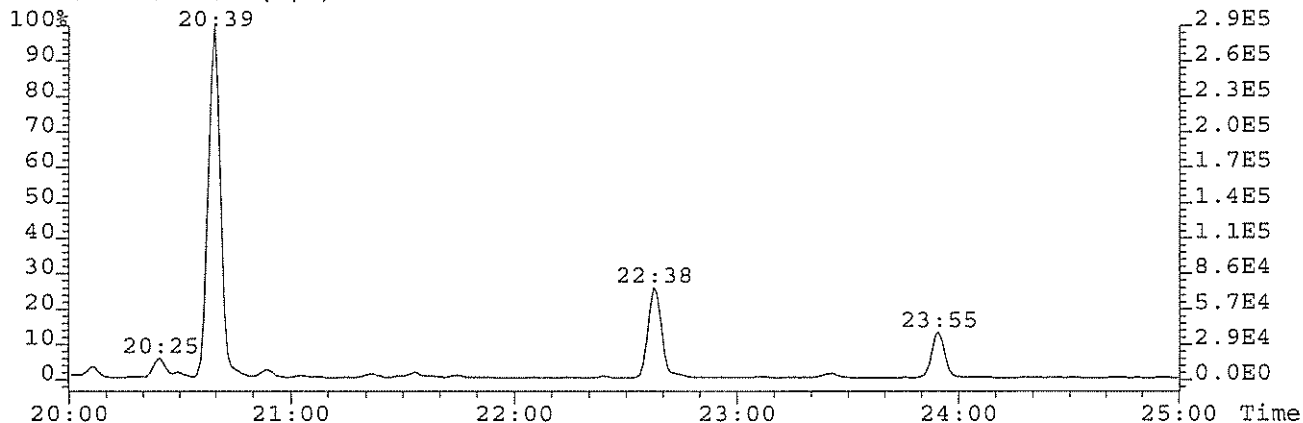
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130716-2 #1-1430 Acq:16-JUL-2013 15:19:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:XE13 0946 3 Exp:RH-PD22

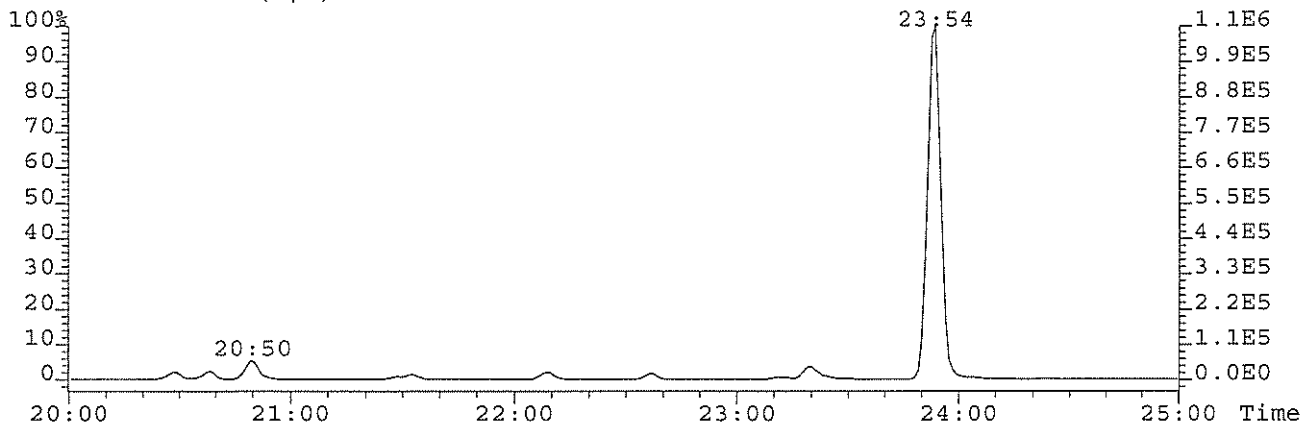
325.8804 S:2 SMO(1,3)



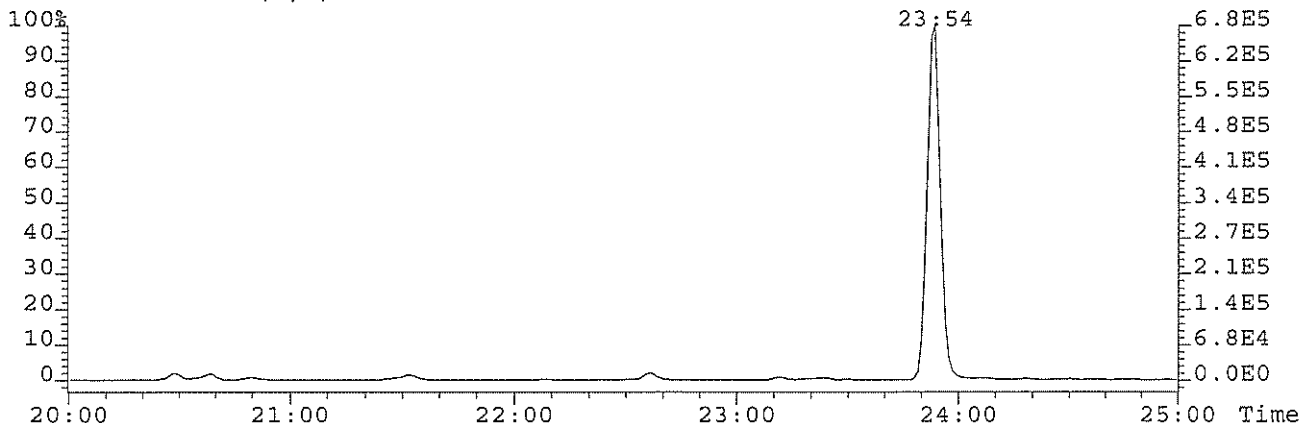
327.8775 S:2 SMO(1,3)



337.9207 S:2 SMO(1,3)

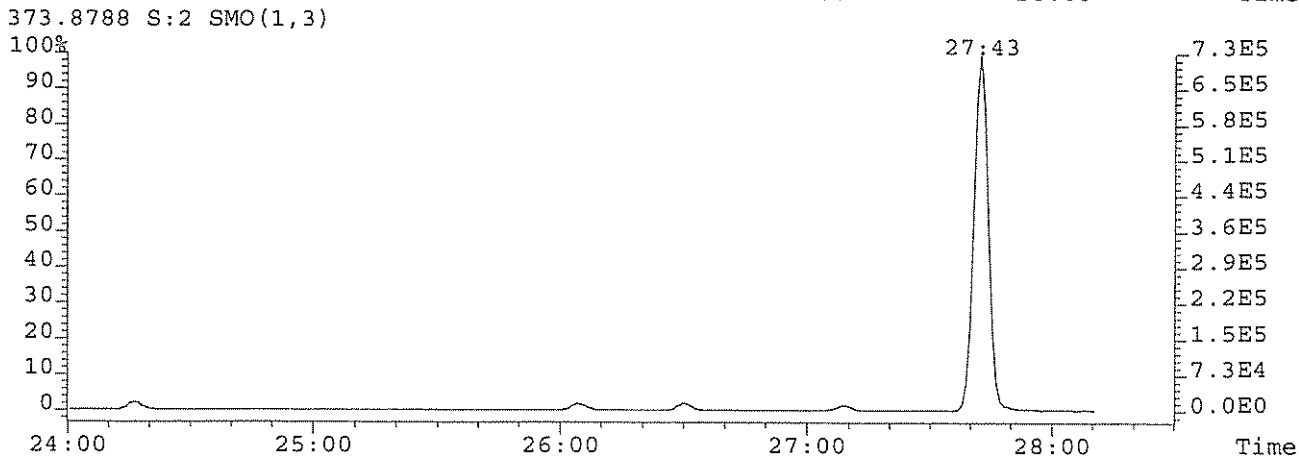
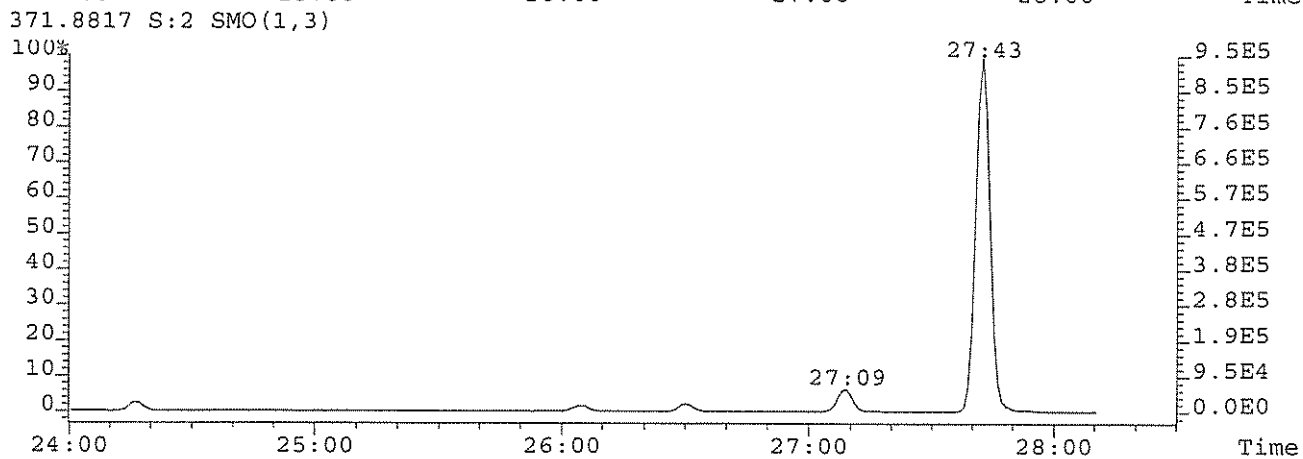
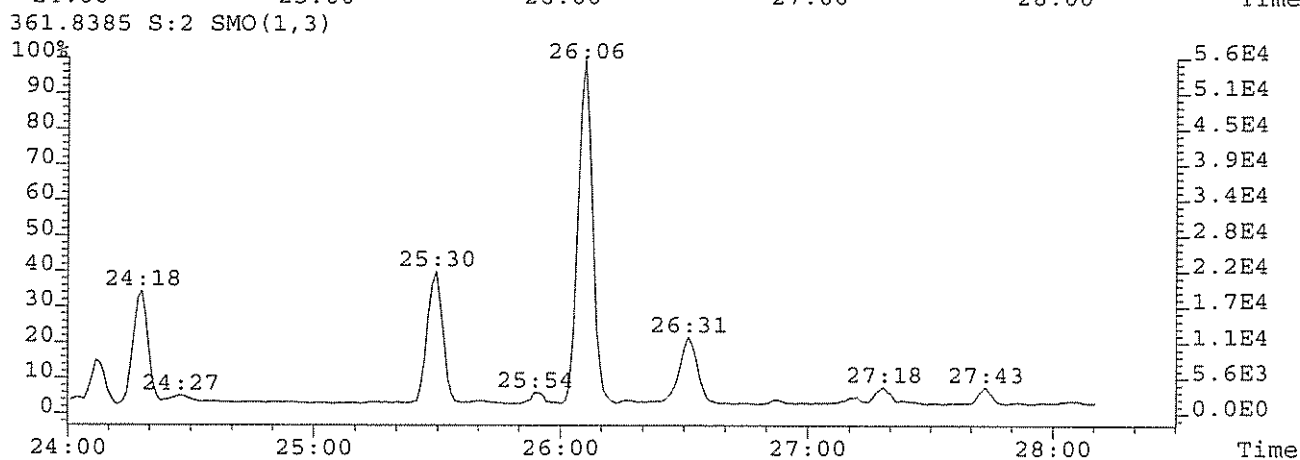
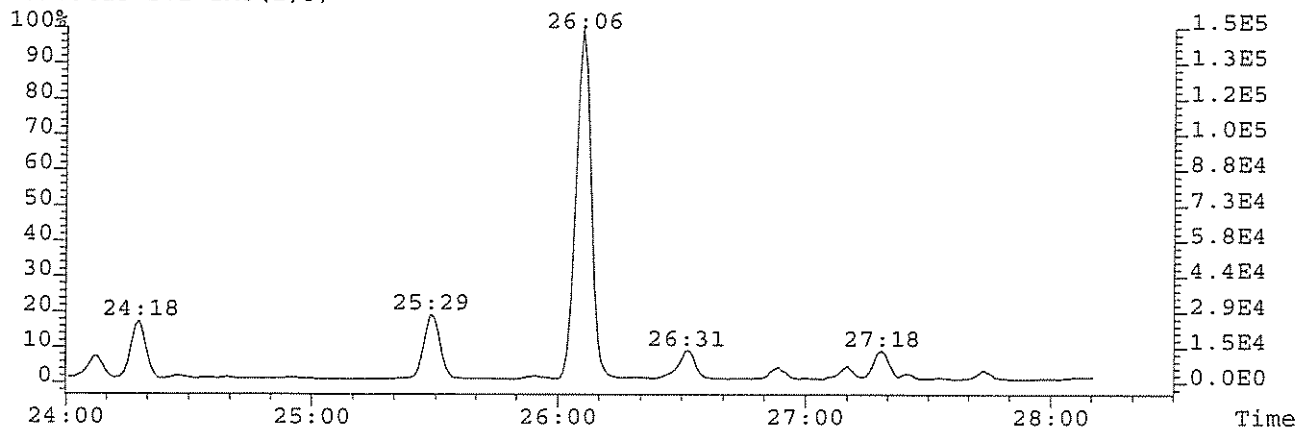


339.9178 S:2 SMO(1,3)



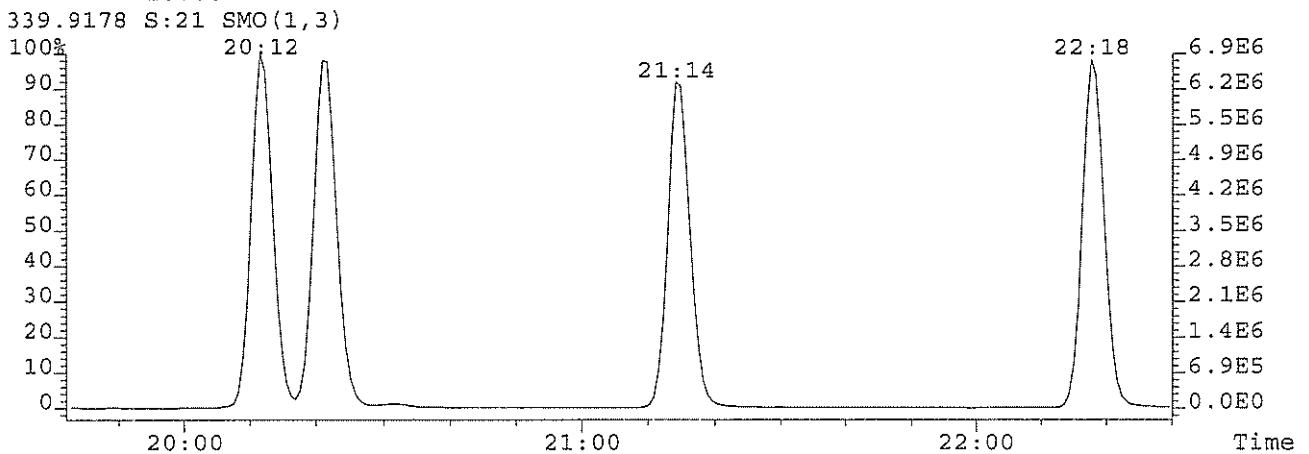
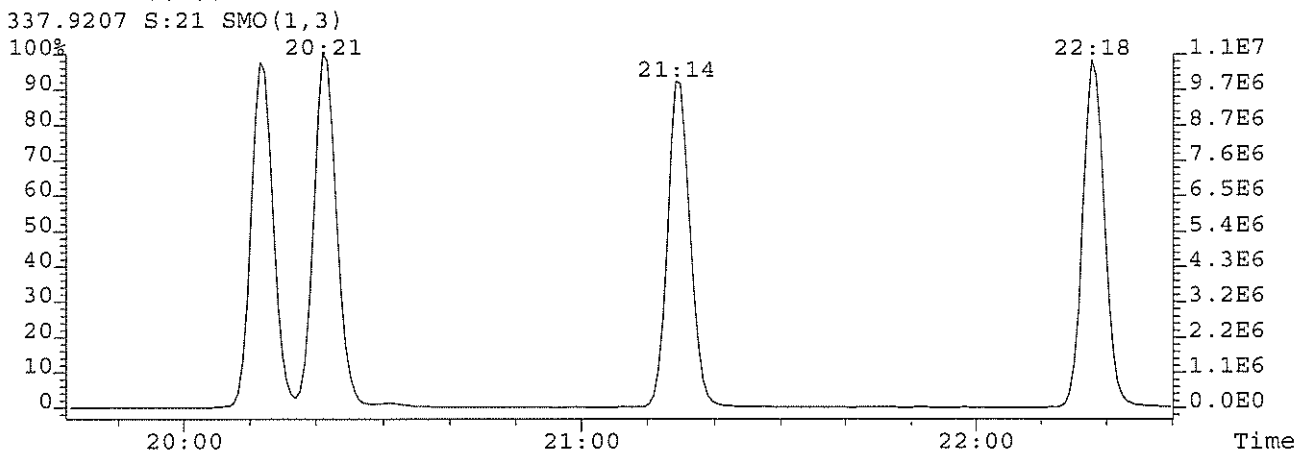
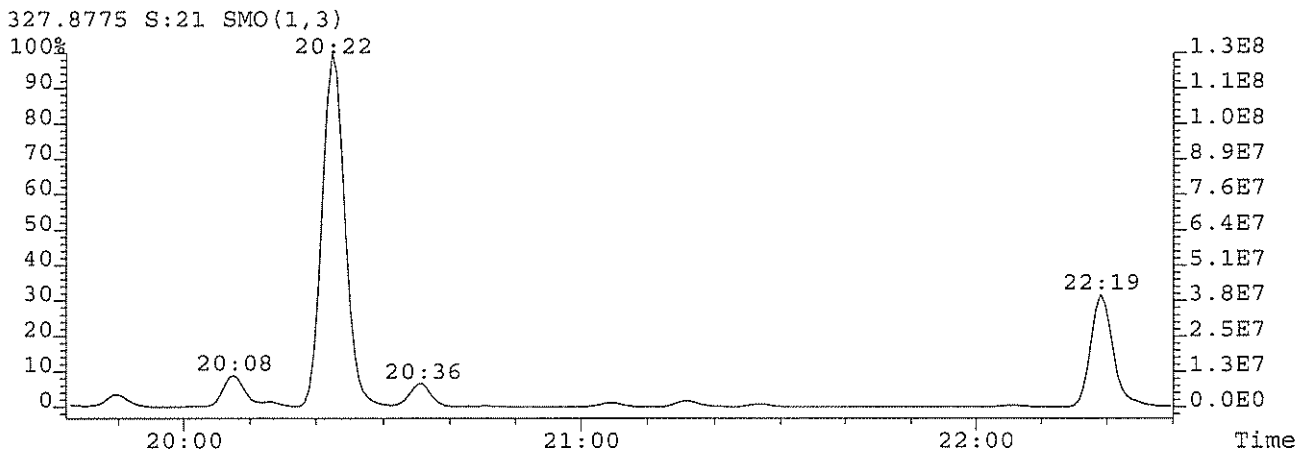
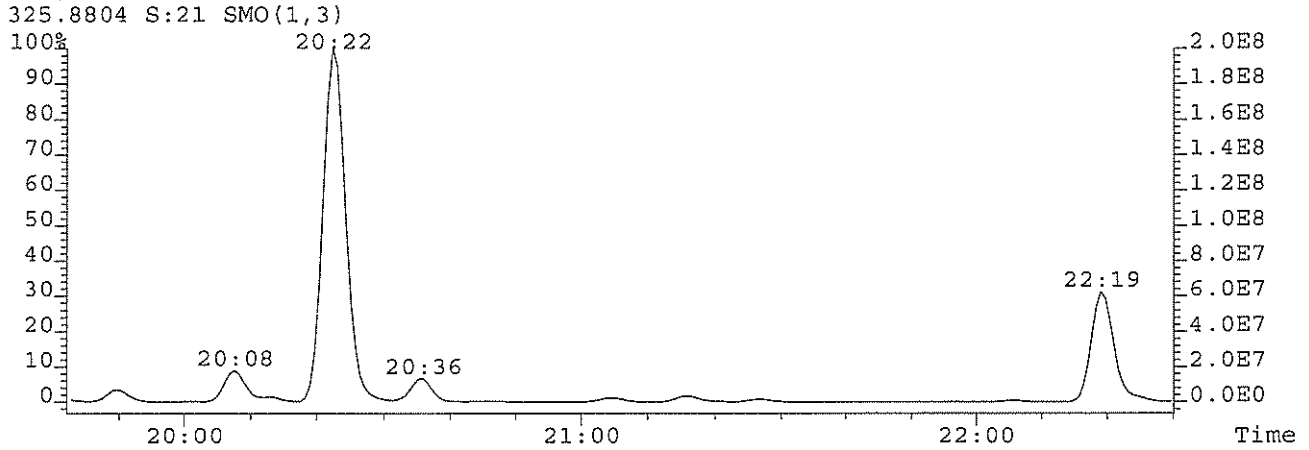
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130716-2 #1-1430 Acq:16-JUL-2013 15:19:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(5-8,nP) Text:XE13 0946 3 Exp:RH-PD22  
359.8415 S:2 SMO(1,3)



DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

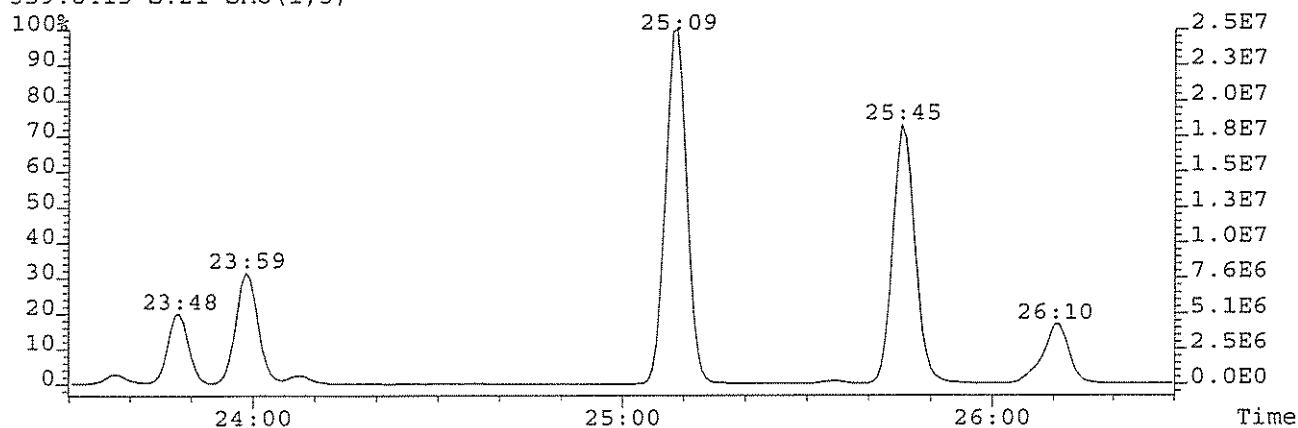
File:130711-2 #1-2897 Acq:12-JUL-2013 08:05:12 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(mP) Text:XE13 0946 2 Exp:RH-MP11



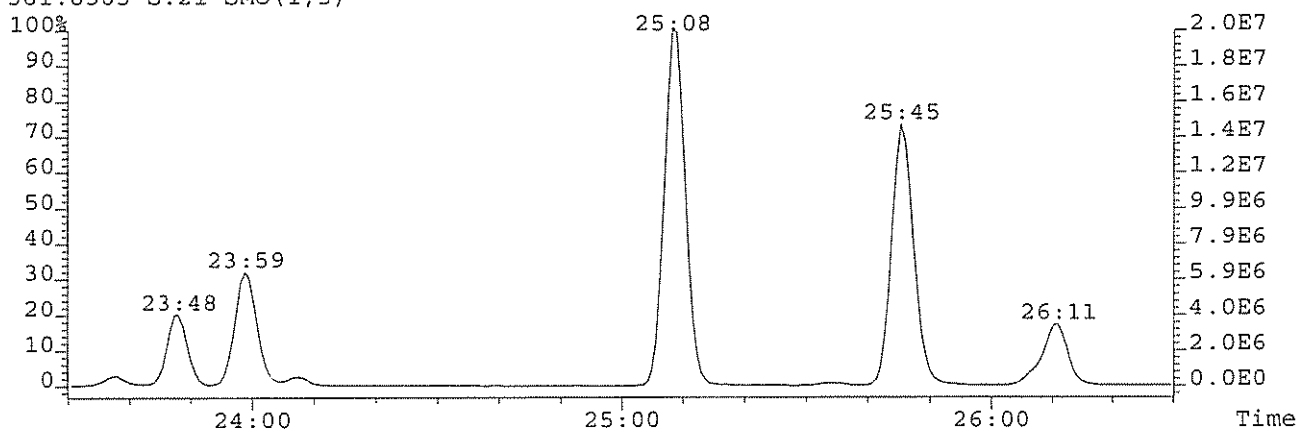
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130711-2 #1-2897 Acq:12-JUL-2013 08:05:12 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(mP) Text:XE13 0946 2 Exp:RH-MP11

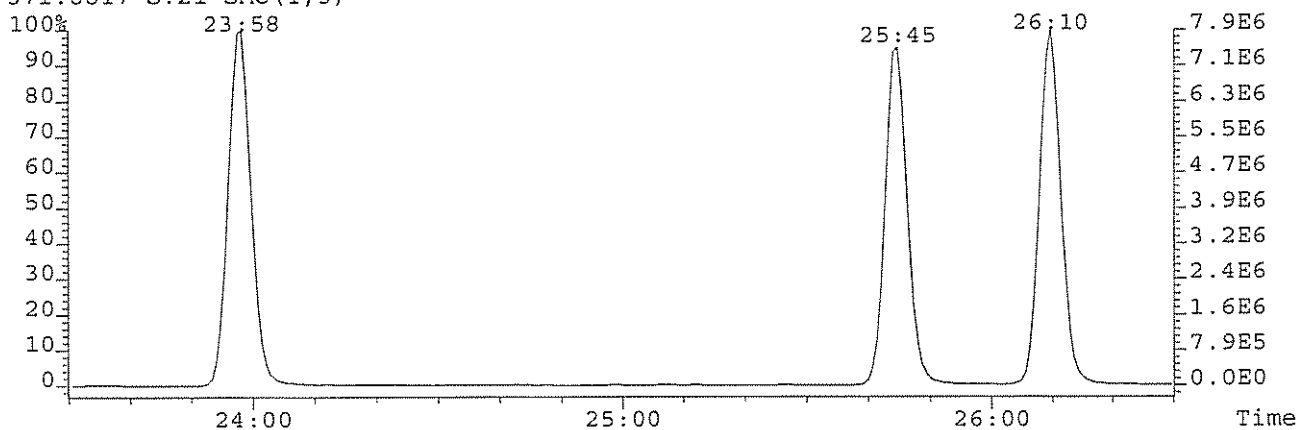
359.8415 S:21 SMO(1,3)



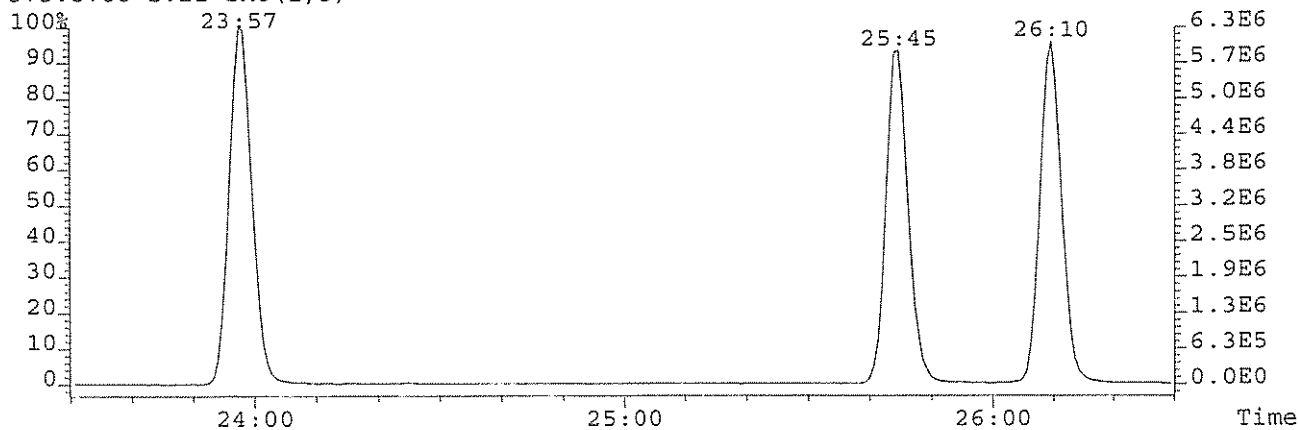
361.8385 S:21 SMO(1,3)



371.8817 S:21 SMO(1,3)

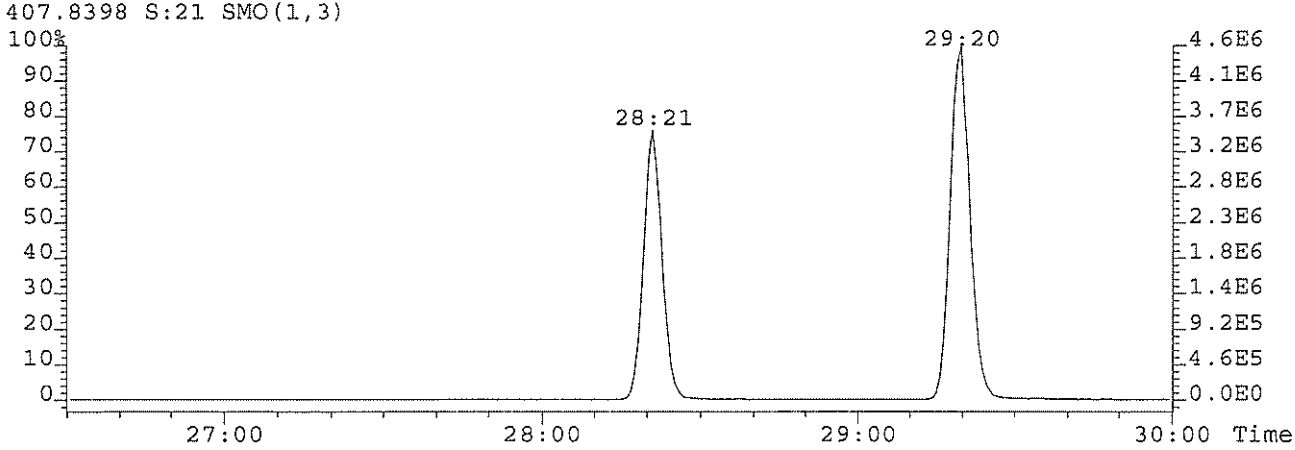
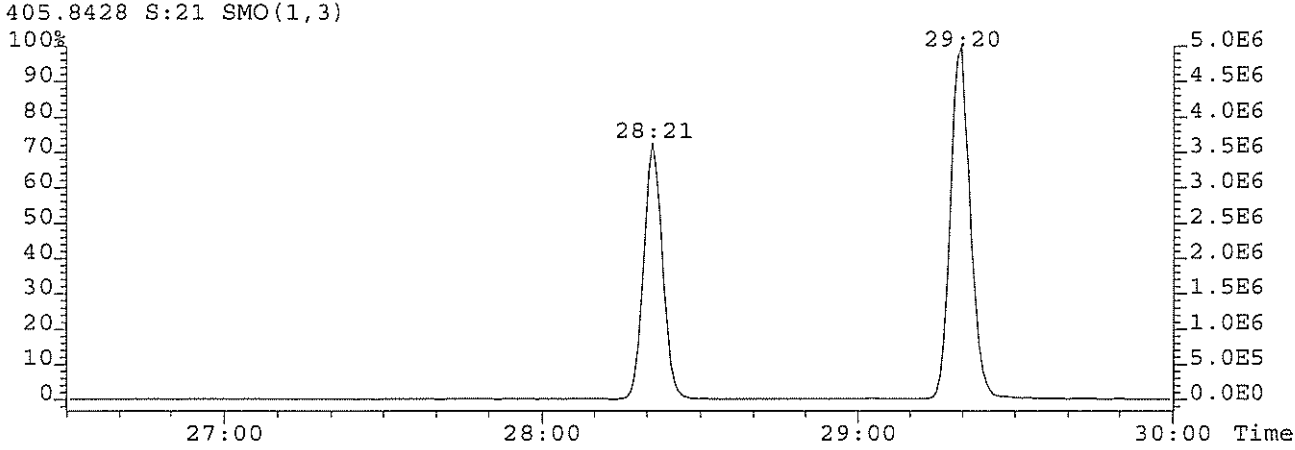
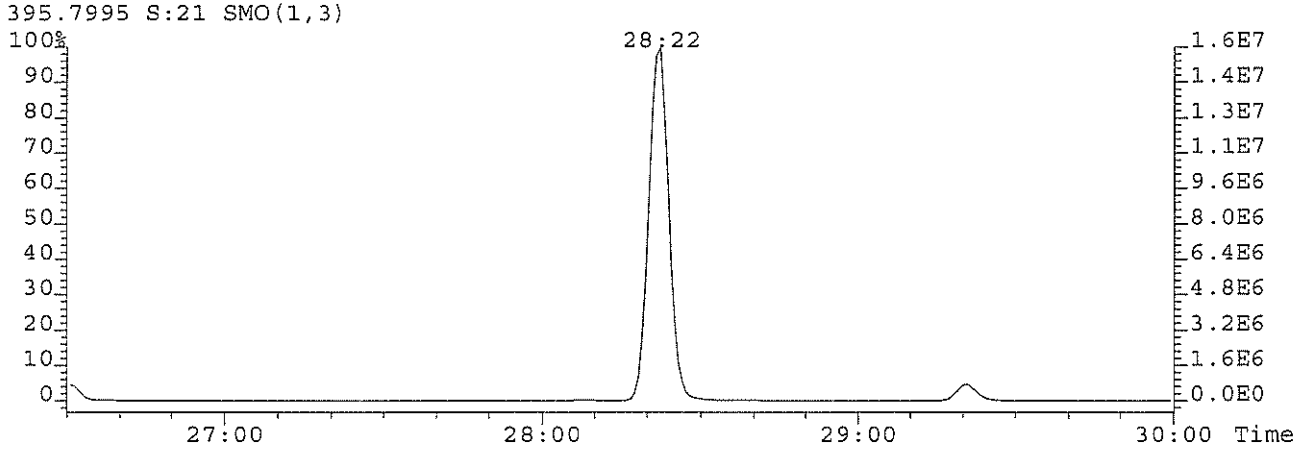
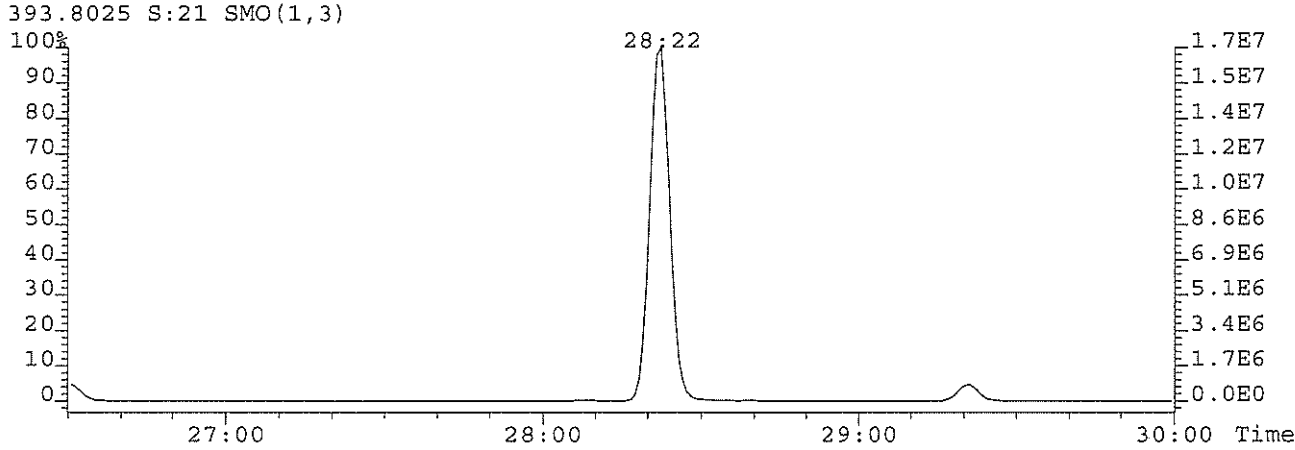


373.8788 S:21 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

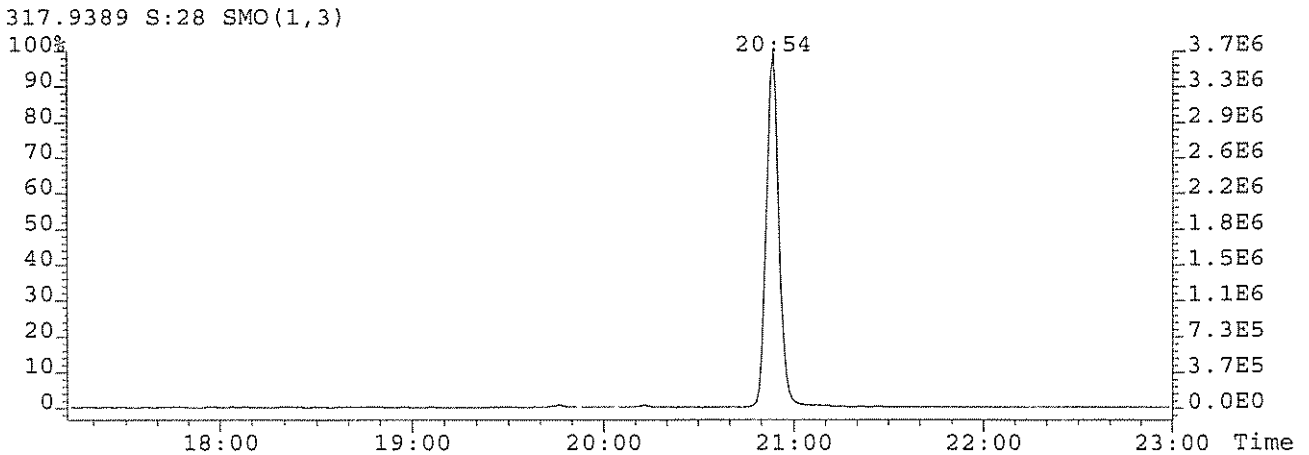
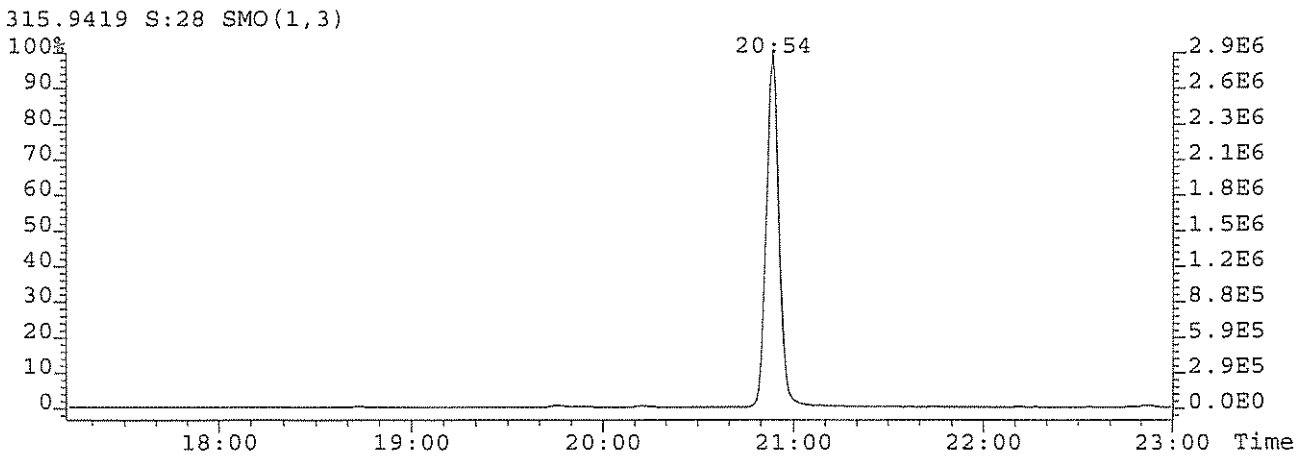
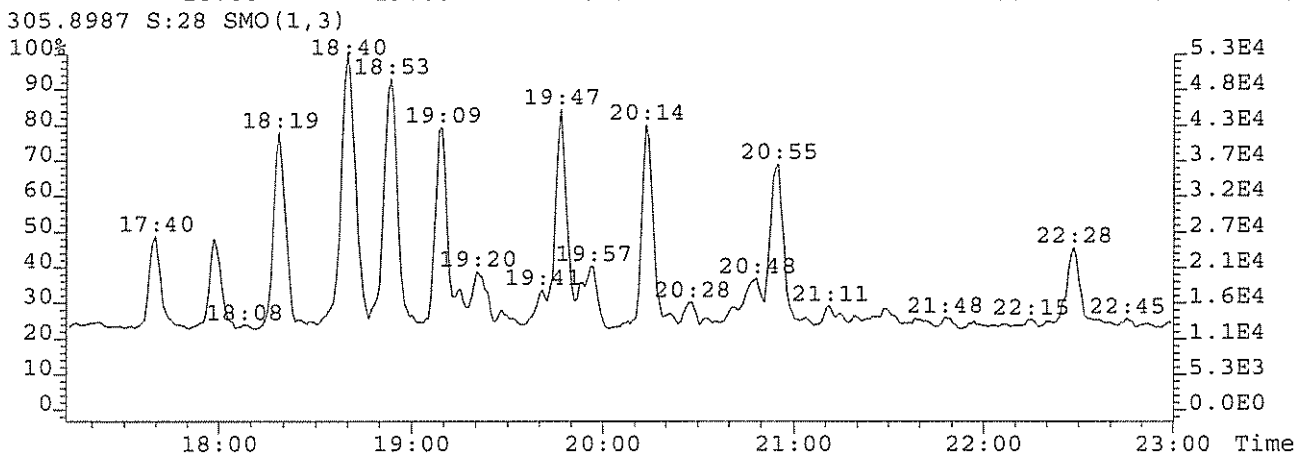
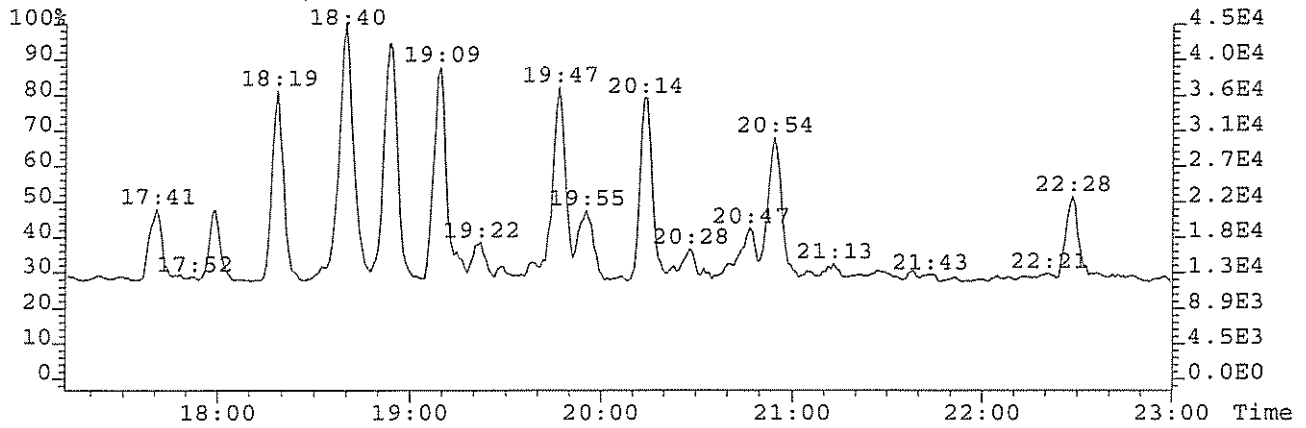
File:130711-2 #1-2897 Acq:12-JUL-2013 08:05:12 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(mP) Text:XE13 0946 2 Exp:RH-MP11



DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

試料管理番号	XE 130947
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.1

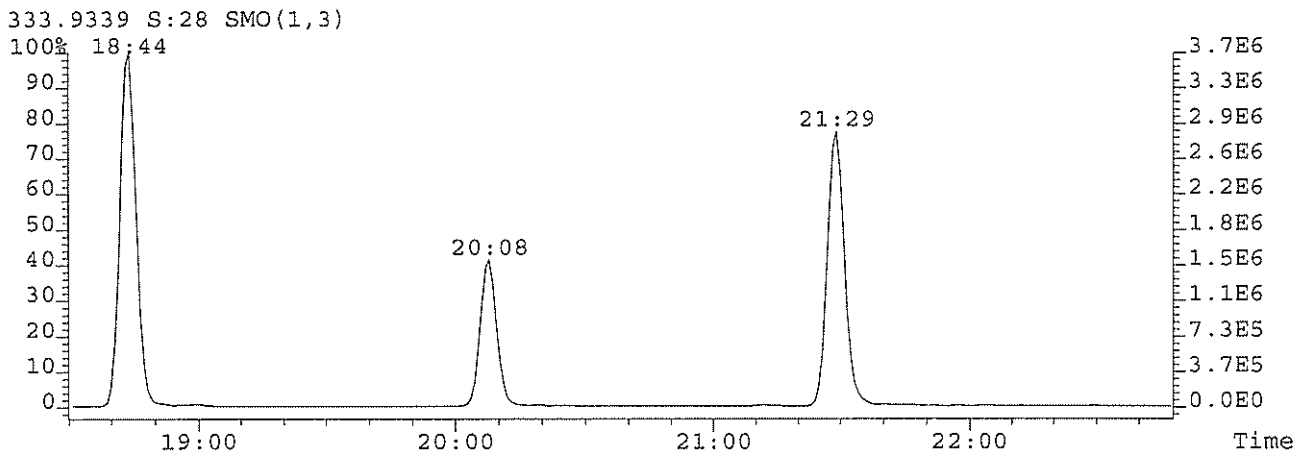
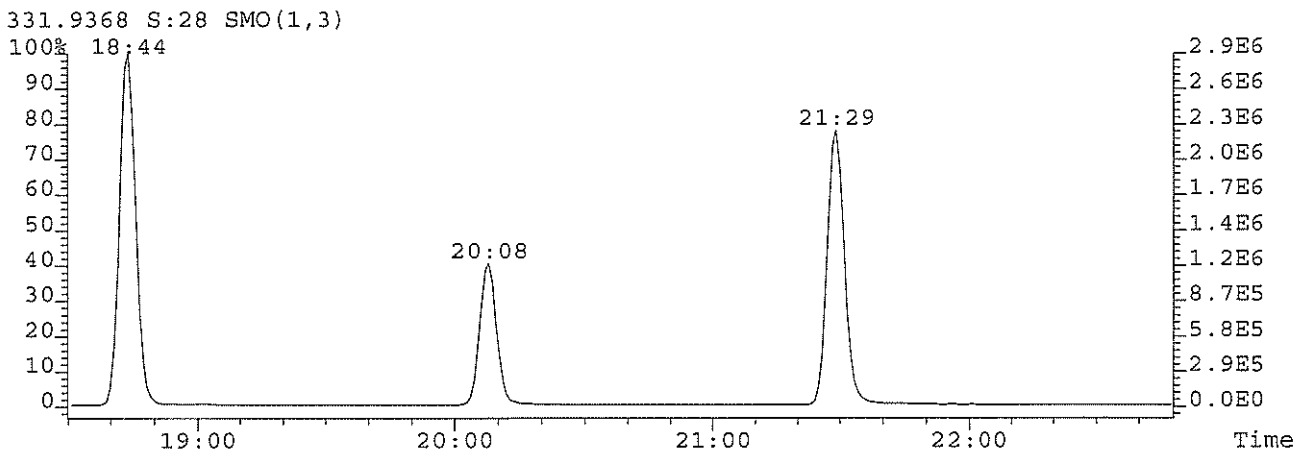
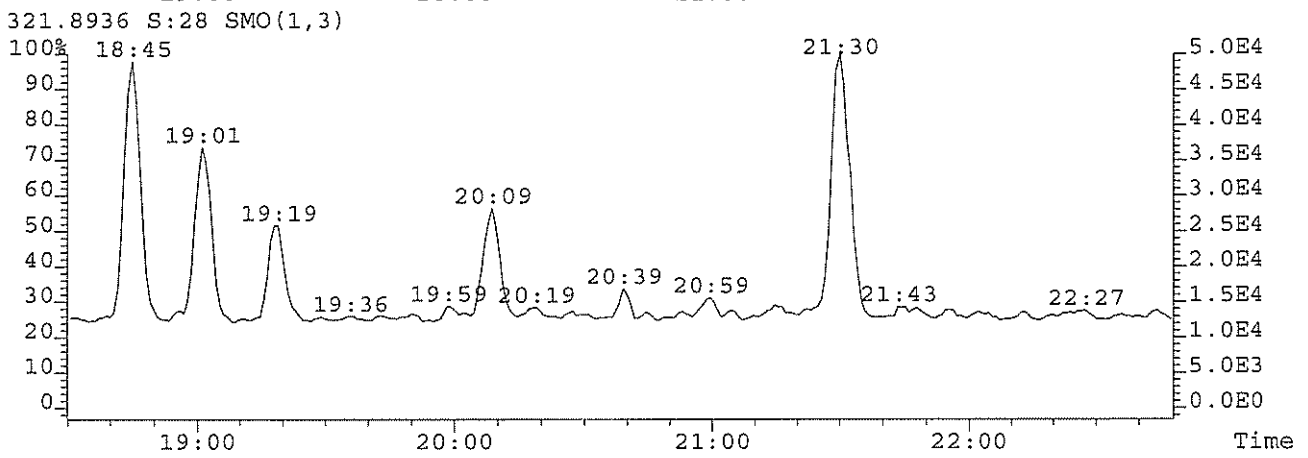
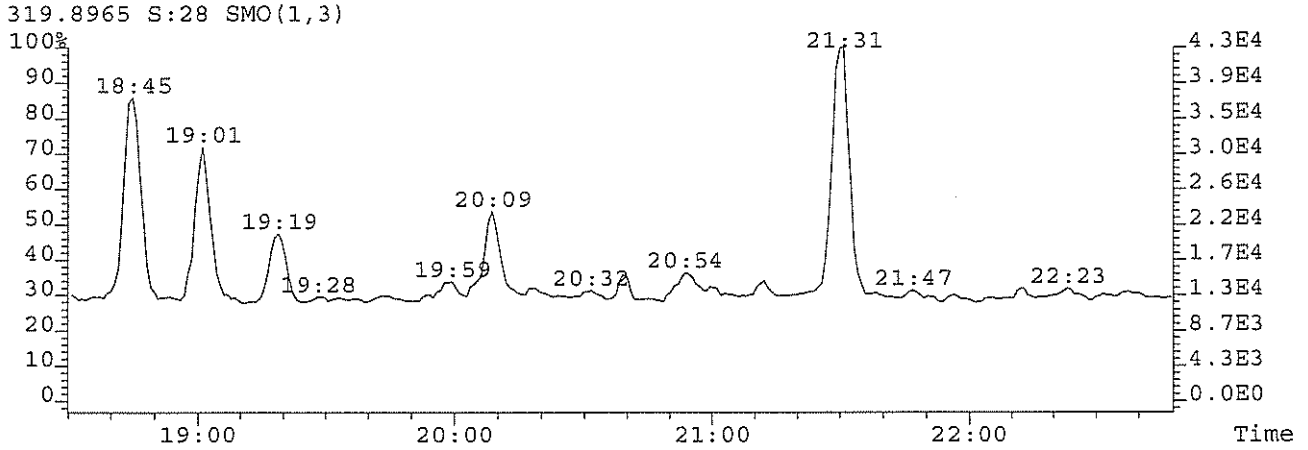
File:130712-2 #1-1578 Acq:13-JUL-2013 13:11:26 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#28 File Text:BPX-DXN(4-6DXN) Text:XE13 0947 Exp:BPX04  
303.9016 S:28 SMO(1,3)



PCDFsクロマトグラム (1)  
(TeCDFs)

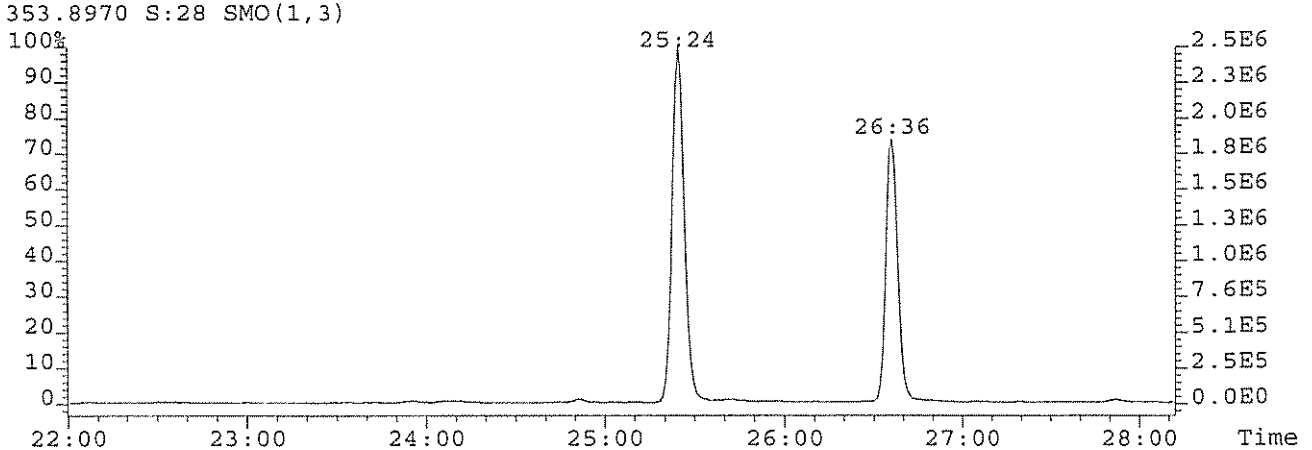
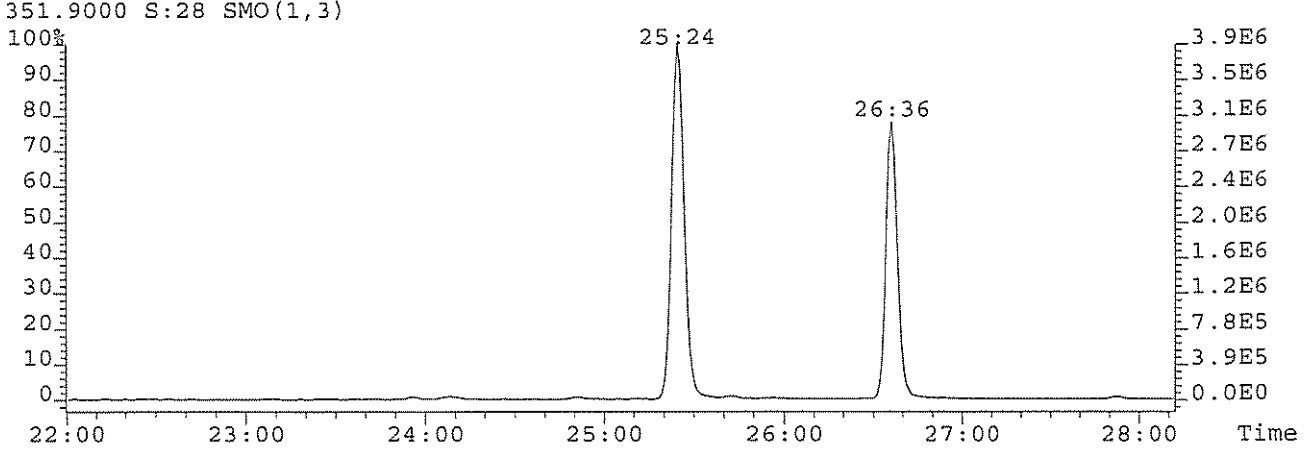
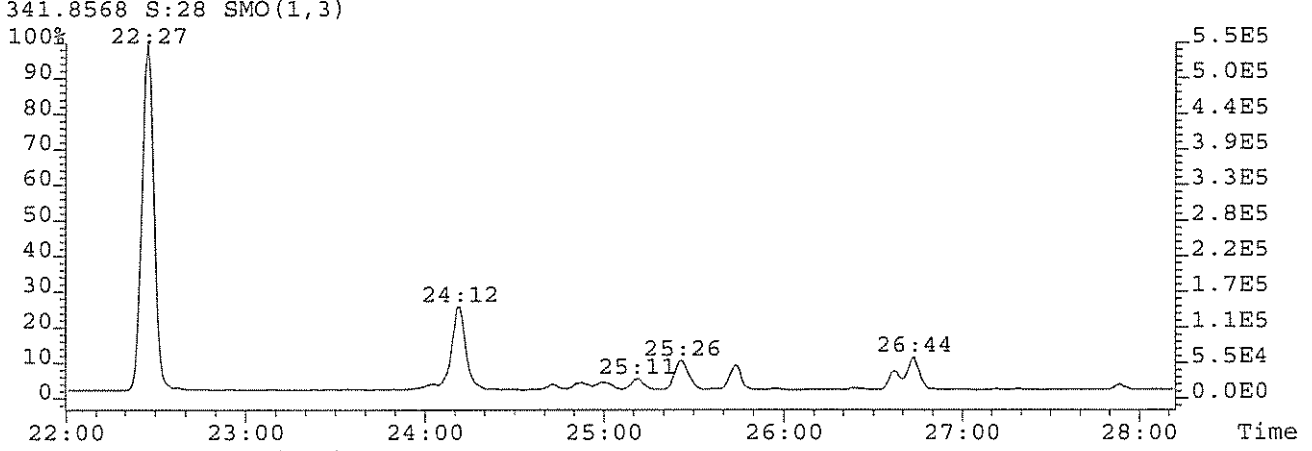
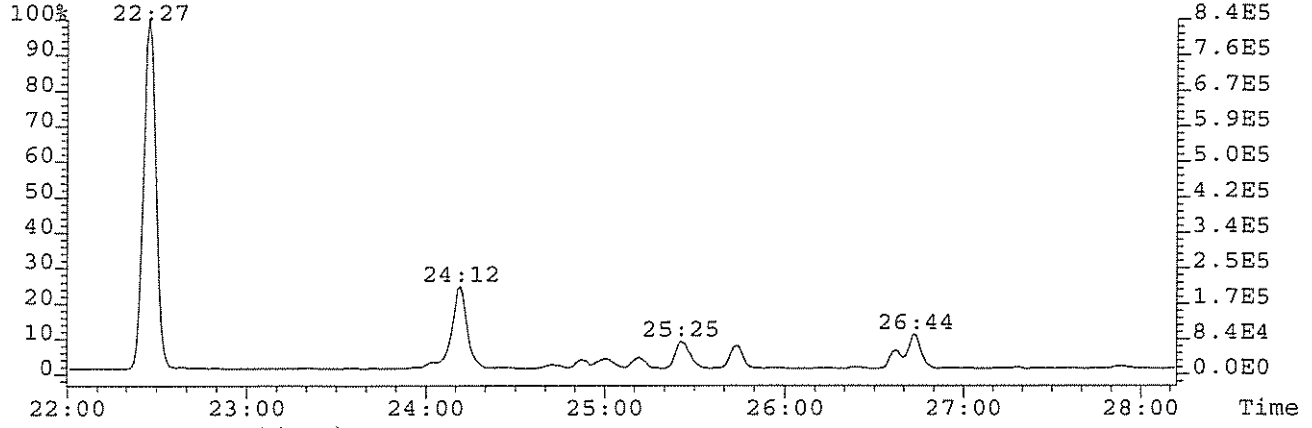


File:130712-2 #1-1578 Acq:13-JUL-2013 13:11:26 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#28 File Text:BPX-DXN(4-6DXN) Text:XE13 0947 Exp:BPX04



PCDDsクロマトグラム (2)  
(TeCDDs)

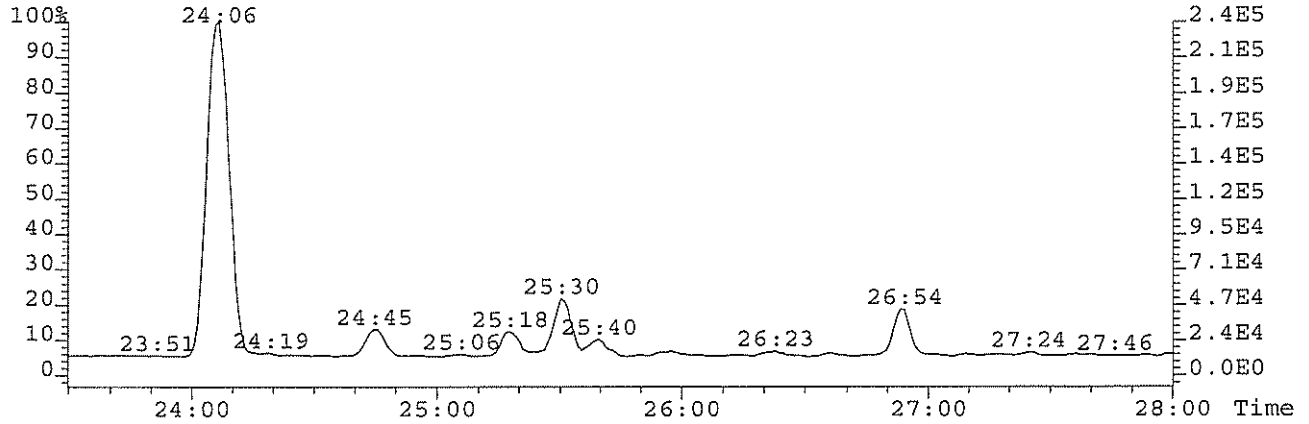
File:130712-2 #1-1578 Acq:13-JUL-2013 13:11:26 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#28 File Text:BPX-DXN(4-6DXN) Text:XE13 0947 Exp:BPX04  
339.8597 S:28 SMO(1,3)



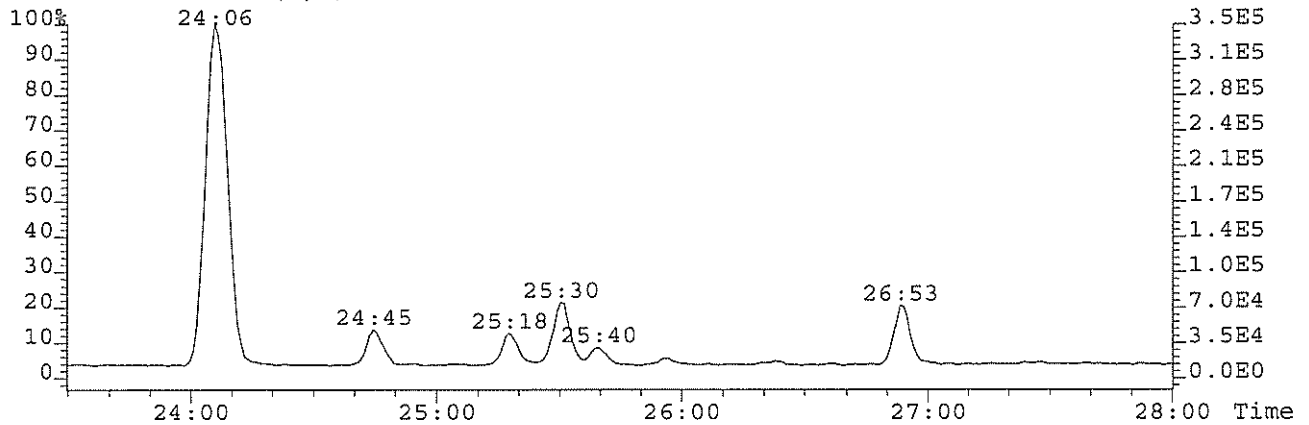
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 13:11:26 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#28 File Text:BPX-DXN(4-6DXN) Text:XE13 0947 Exp:BPX04

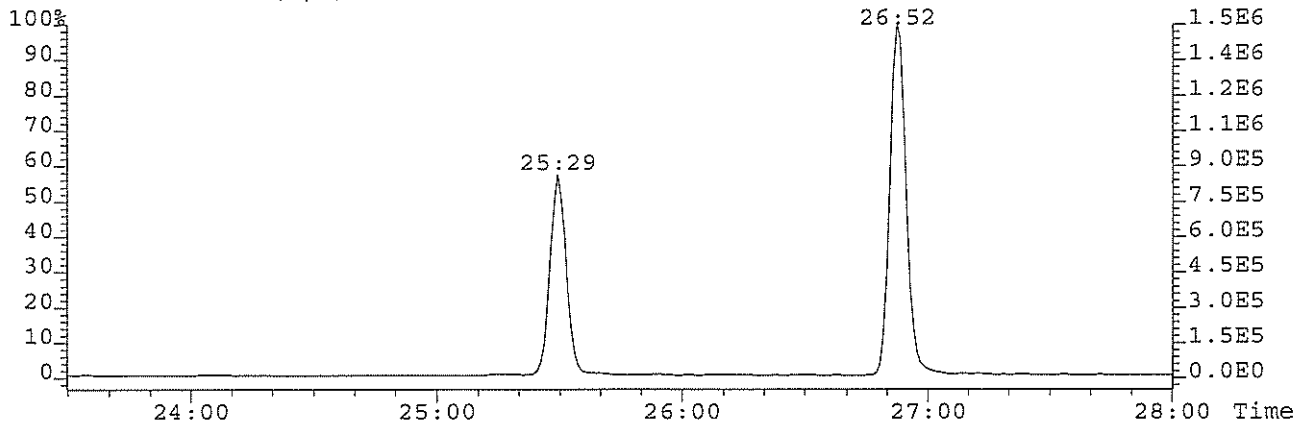
353.8576 S:28 SMO(1,3)



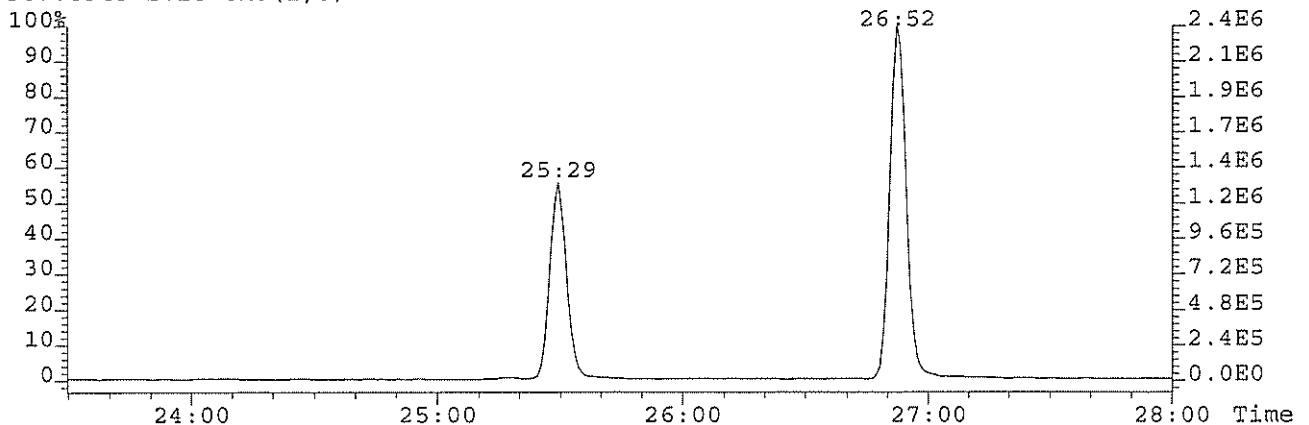
355.8546 S:28 SMO(1,3)



365.8978 S:28 SMO(1,3)



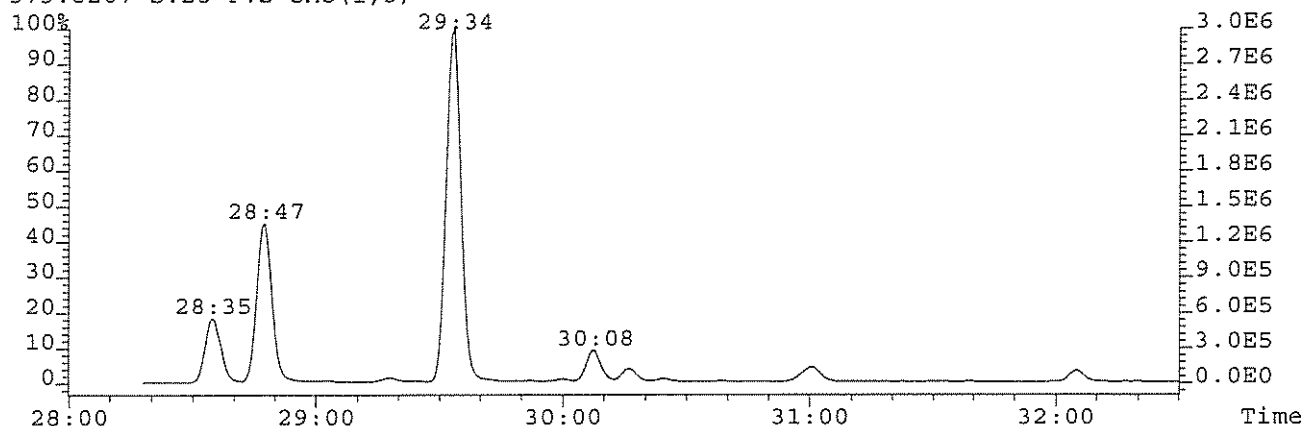
367.8949 S:28 SMO(1,3)



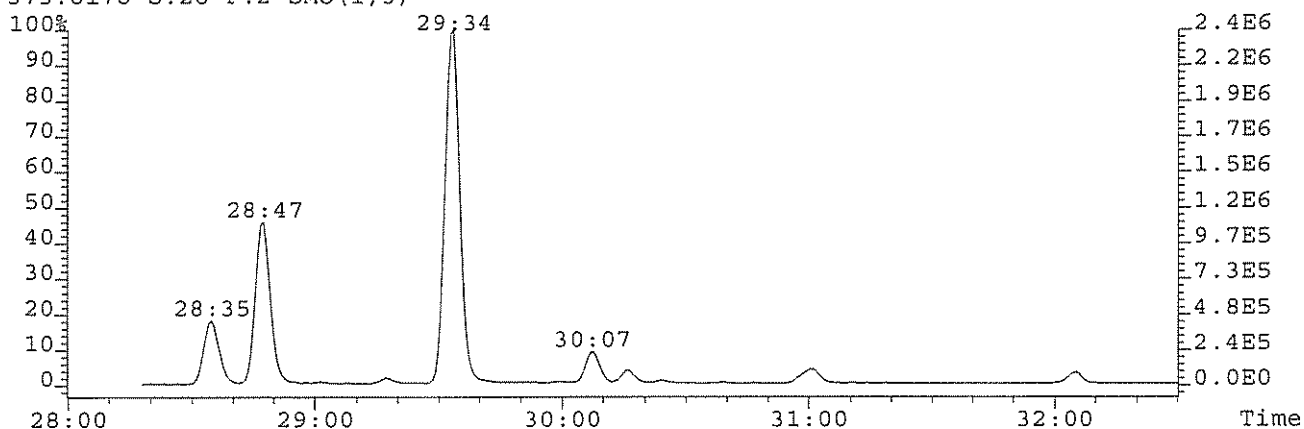
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130712-2 #1-1117 Acq:13-JUL-2013 13:11:26 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#28 File Text:BPX-DXN(4-6DXN) Text:XE13 0947 Exp:BPX04

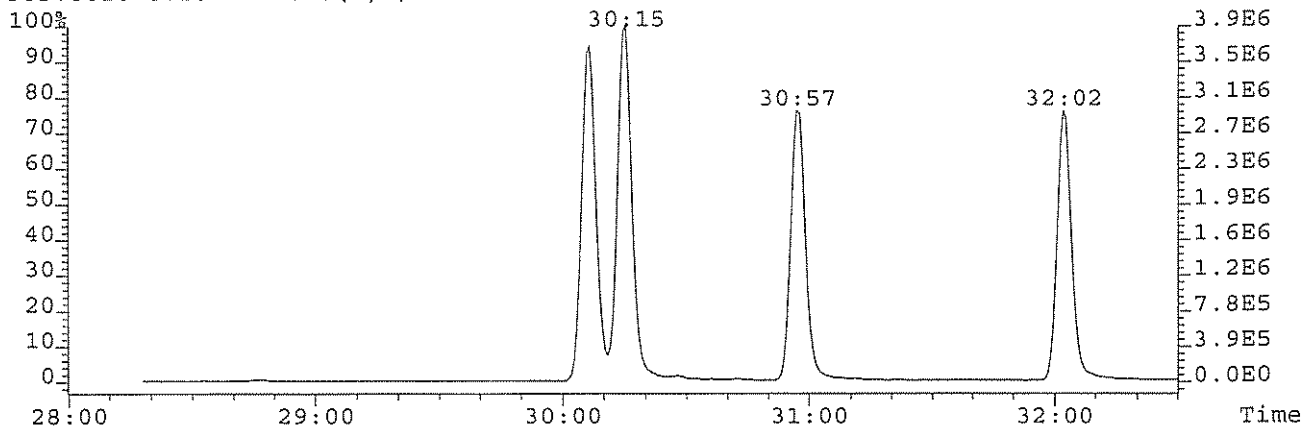
373.8207 S:28 F:2 SMO(1,3)



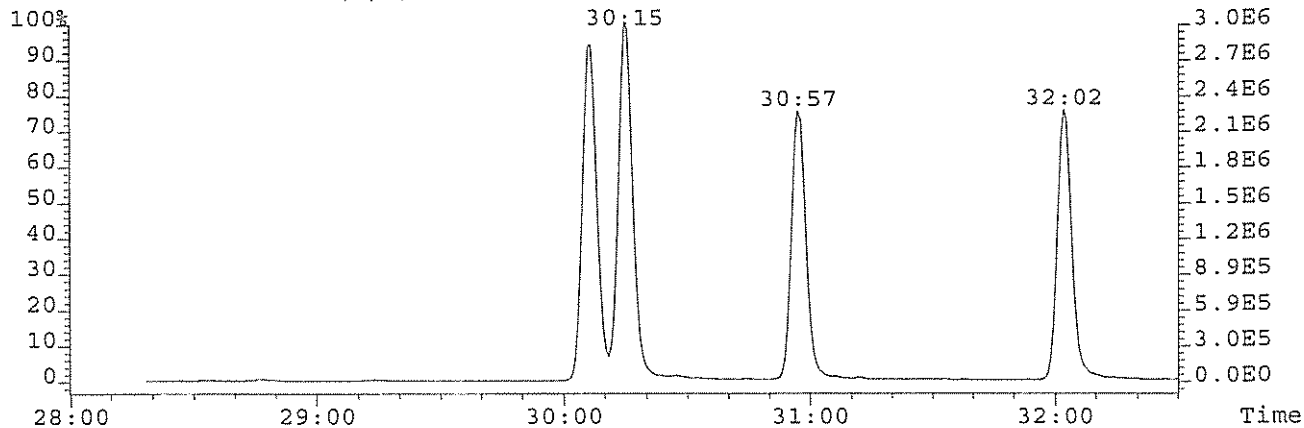
375.8178 S:28 F:2 SMO(1,3)



385.8610 S:28 F:2 SMO(1,3)



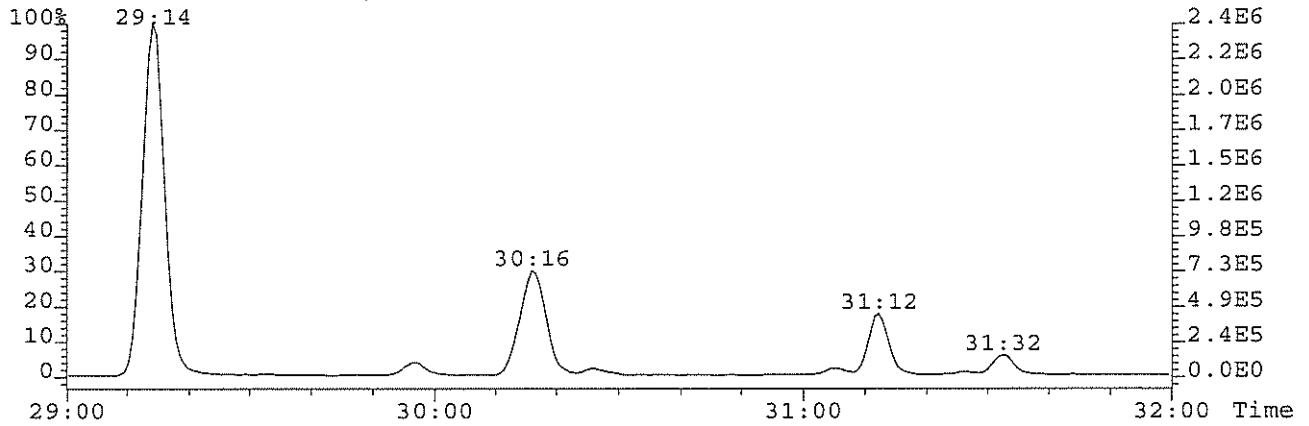
387.8580 S:28 F:2 SMO(1,3)



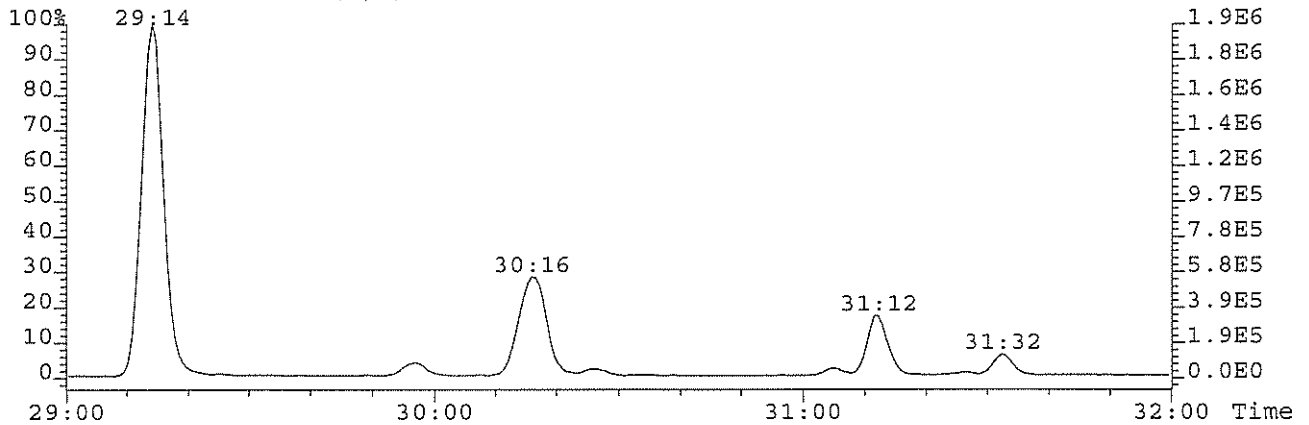
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1117 Acq:13-JUL-2013 13:11:26 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#28 File Text:BPX-DXN(4-6DXN) Text:XE13 0947 Exp:BPX04

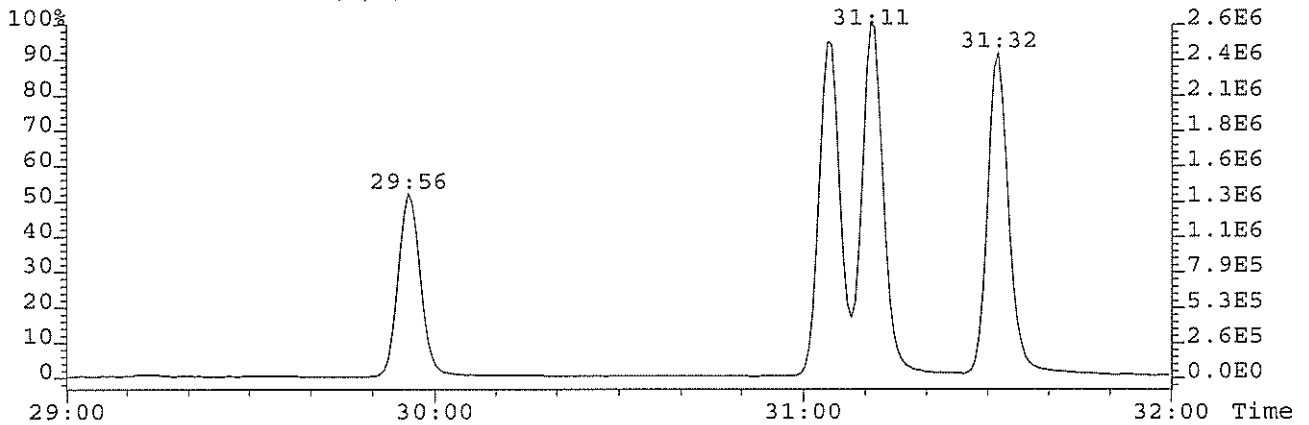
389.8156 S:28 F:2 SMO(1,3)



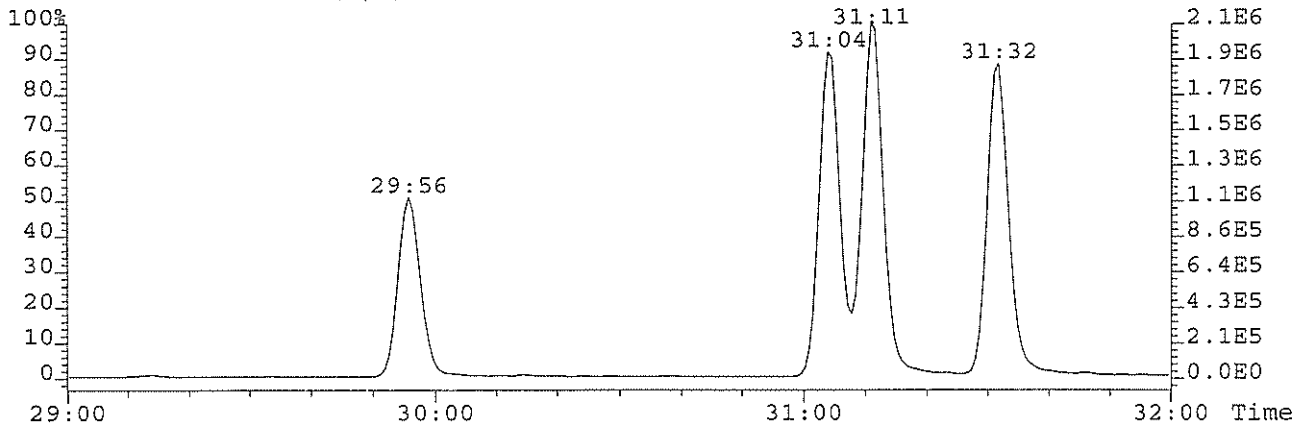
391.8127 S:28 F:2 SMO(1,3)



401.8559 S:28 F:2 SMO(1,3)

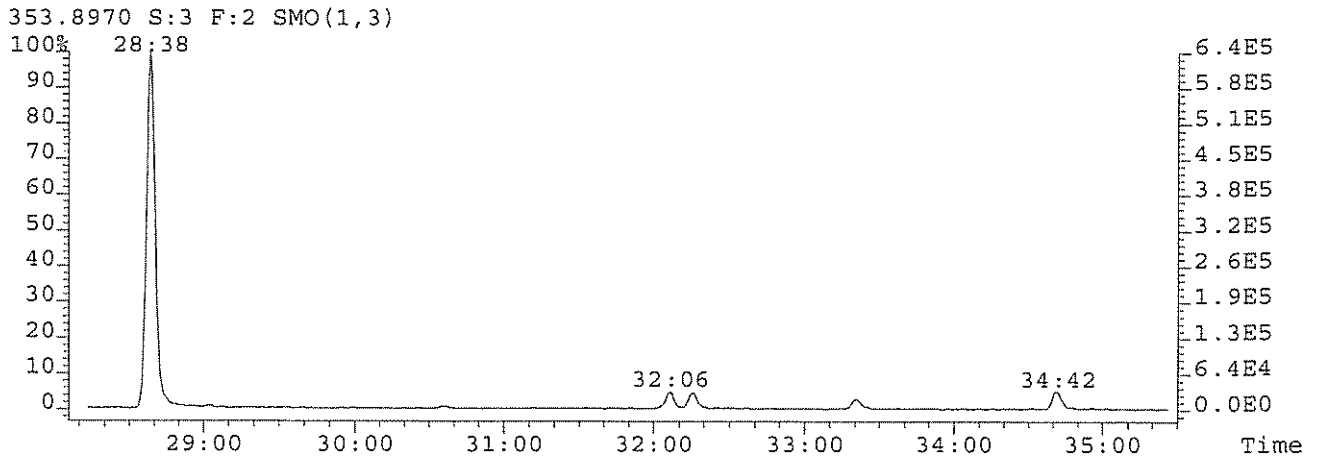
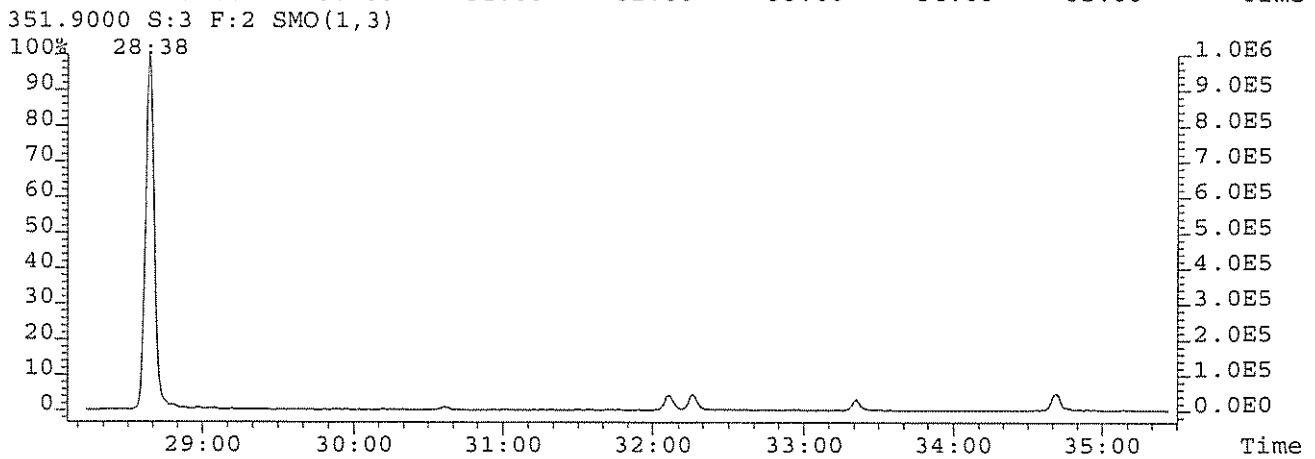
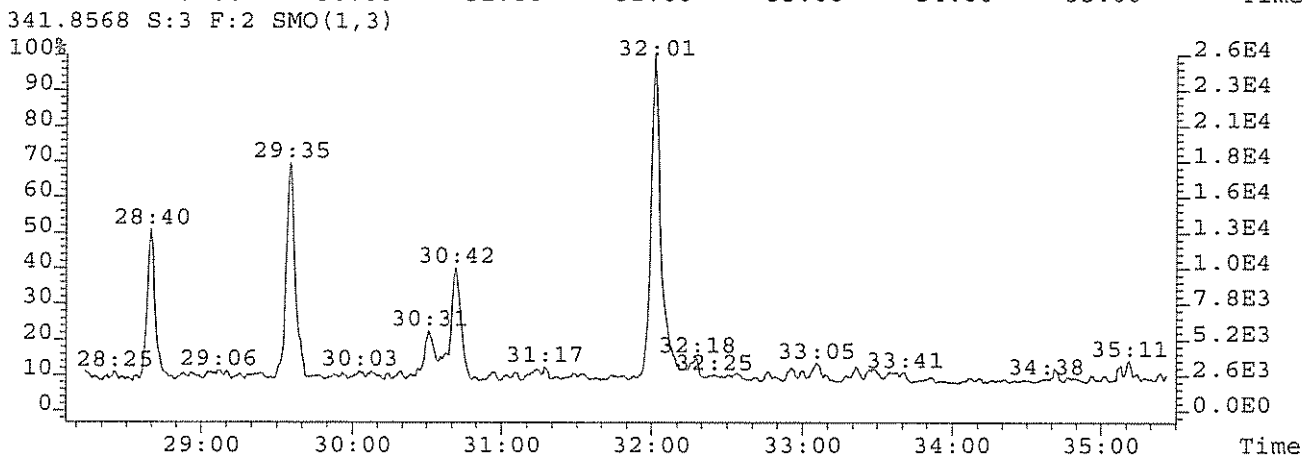
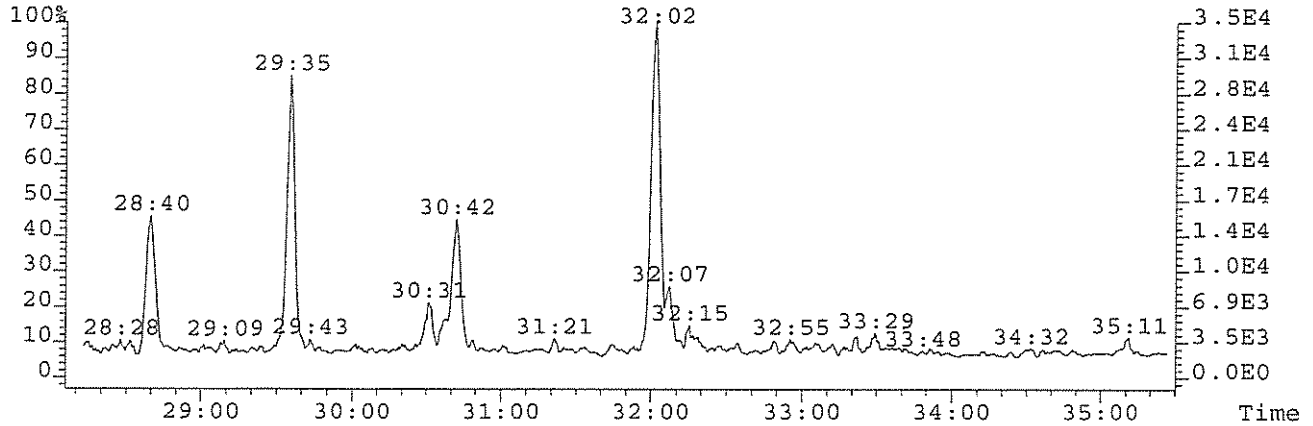


403.8530 S:28 F:2 SMO(1,3)



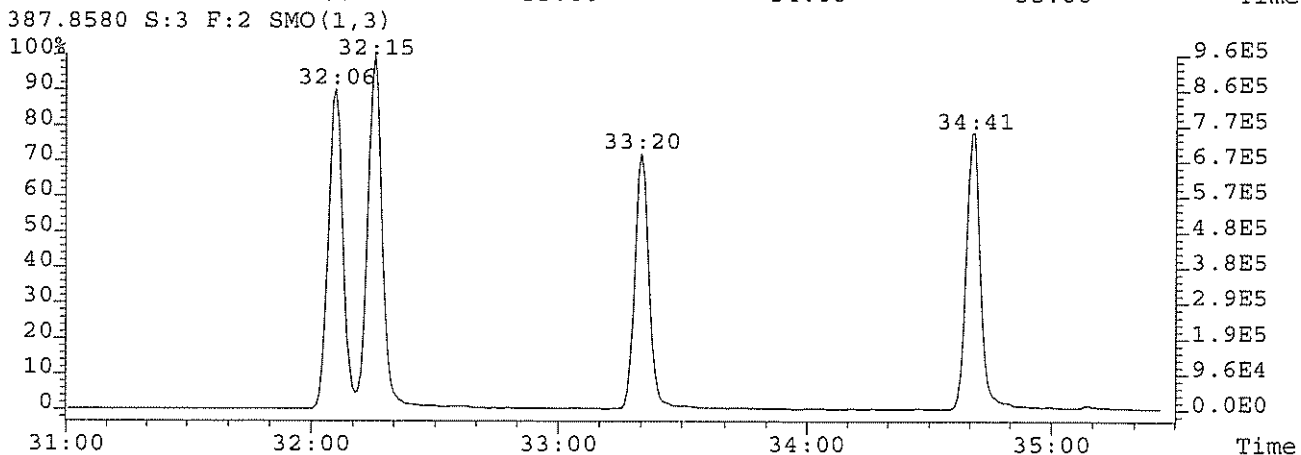
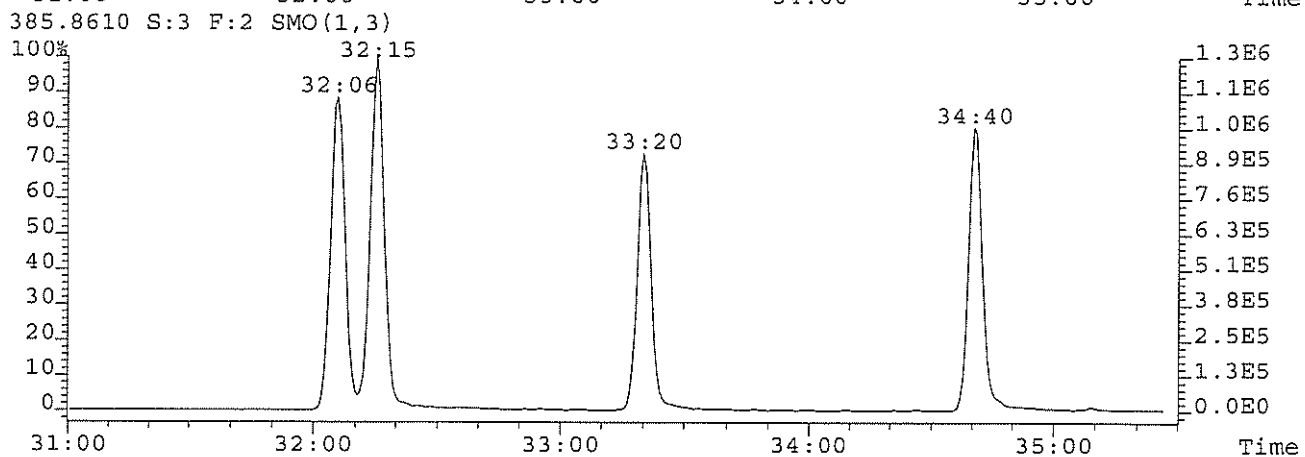
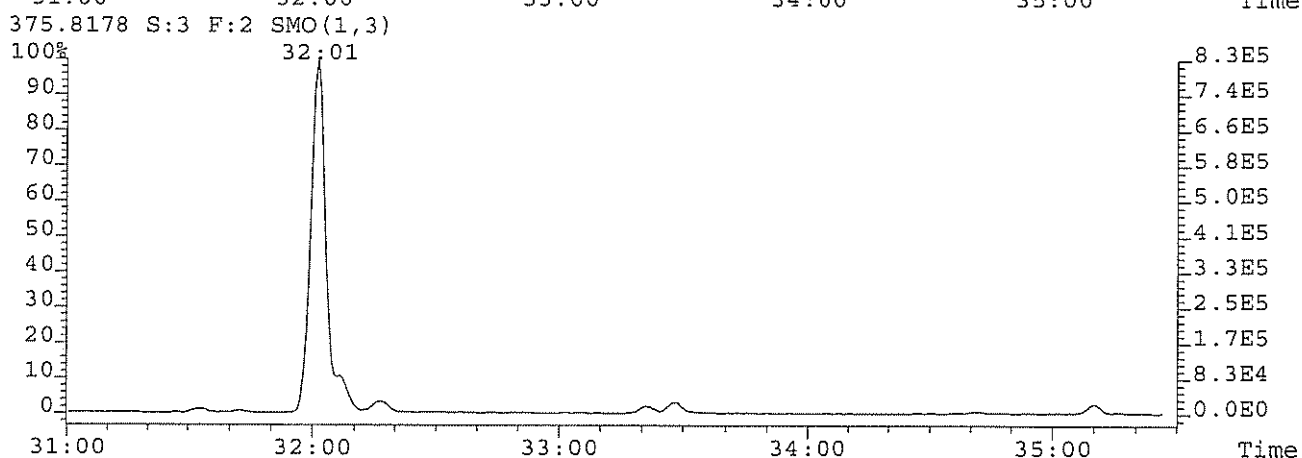
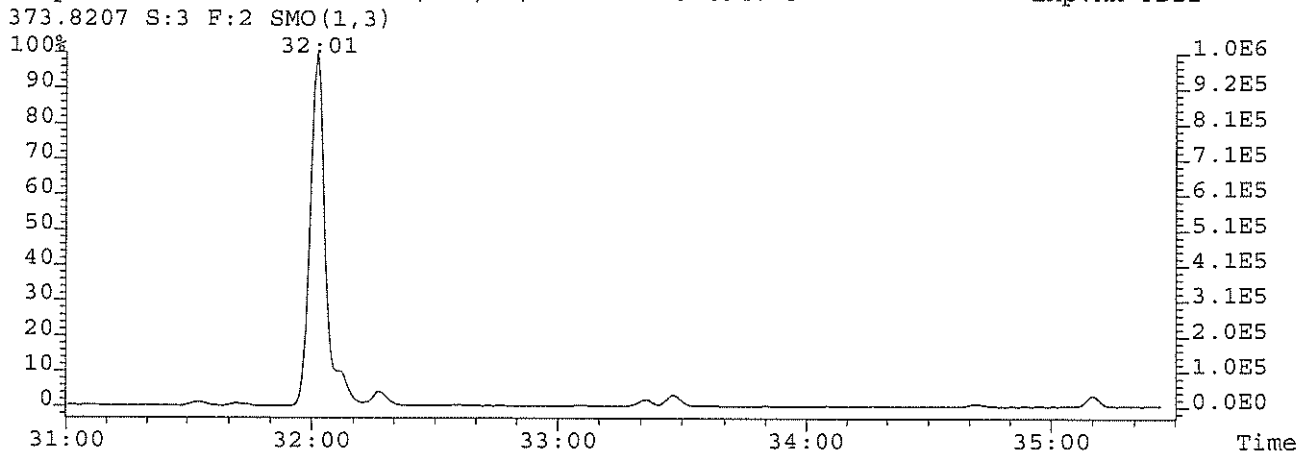
PCDDsクロマトグラム (6)  
(HxCDDs)

File:130716-2 #1-649 Acq:16-JUL-2013 16:08:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#3 File Text:RH-12ms(5-8,nP) Text:XE13 0947 3 Exp:RH-PD22  
339.8597 S:3 F:2 SMO(1,3)



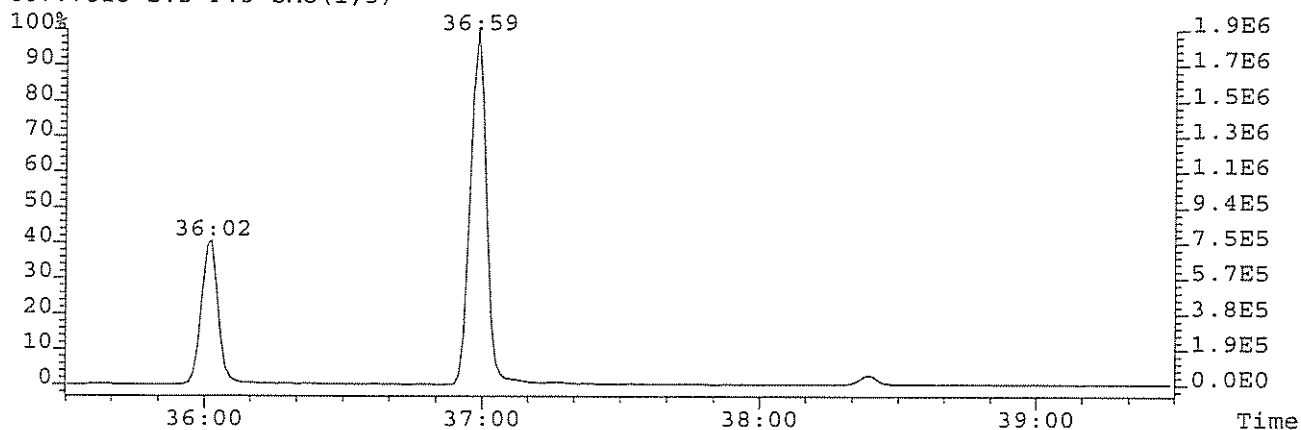
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130716-2 #1-649 Acq:16-JUL-2013 16:08:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#3 File Text:RH-12ms(5-8,nP) Text:XE13 0947 3 Exp:RH-PD22

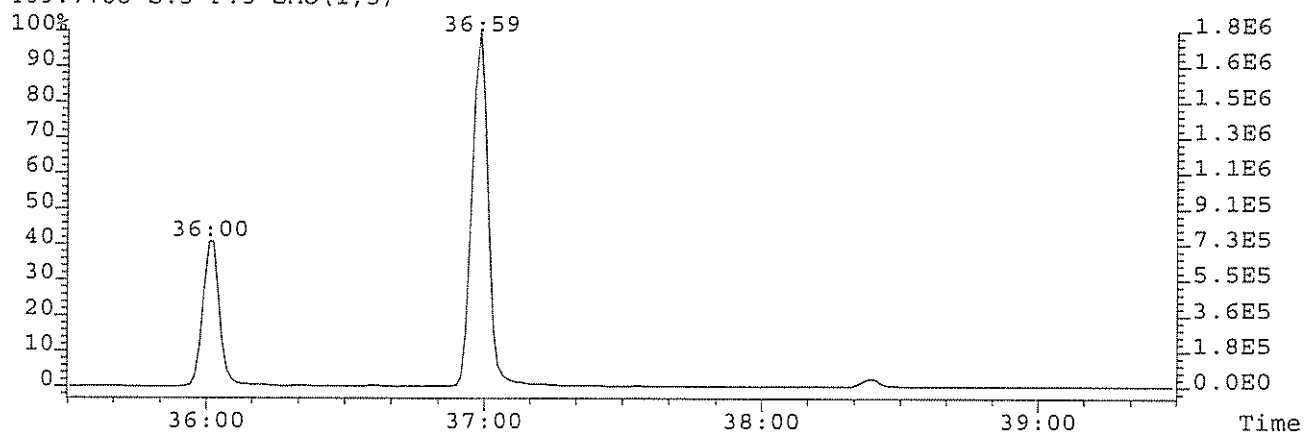


HxCDFsクロマトグラム (8)  
(123789-HxCDF)

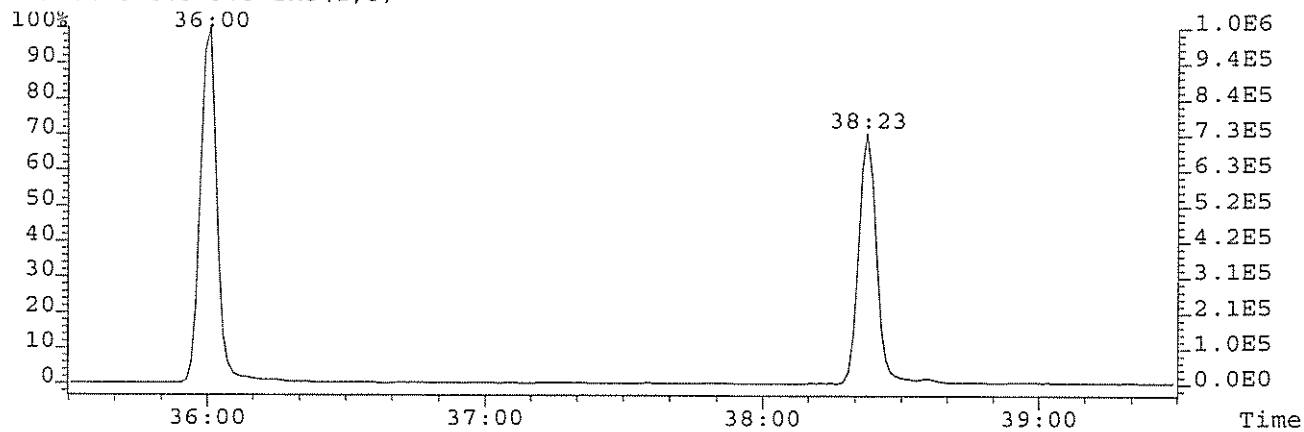
File:130716-2 #1-562 Acq:16-JUL-2013 16:08:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#3 File Text:RH-12ms(5-8,nP) Text:XE13 0947 3 Exp:RH-PD22  
407.7818 S:3 F:3 SMO(1,3)



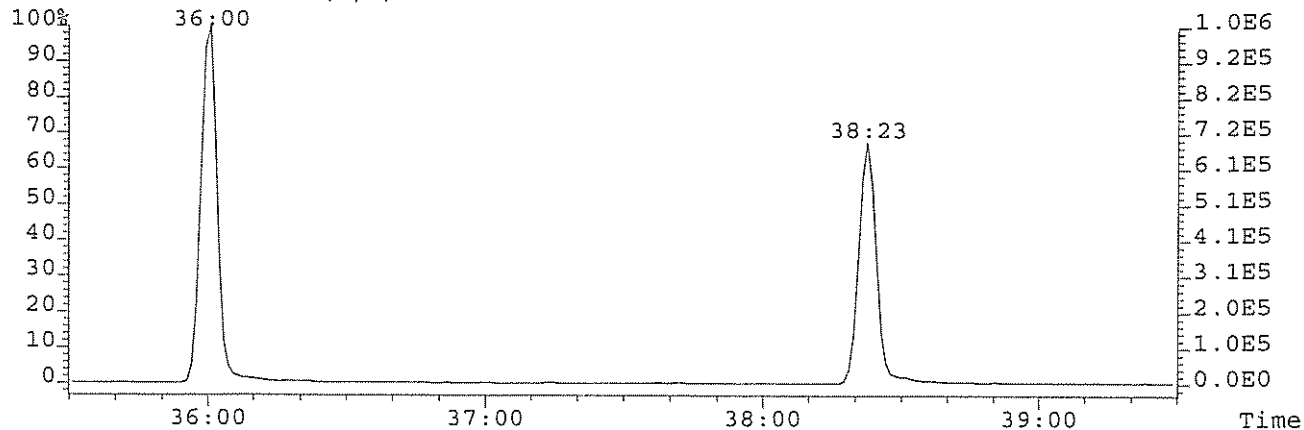
409.7788 S:3 F:3 SMO(1,3)



419.8220 S:3 F:3 SMO(1,3)



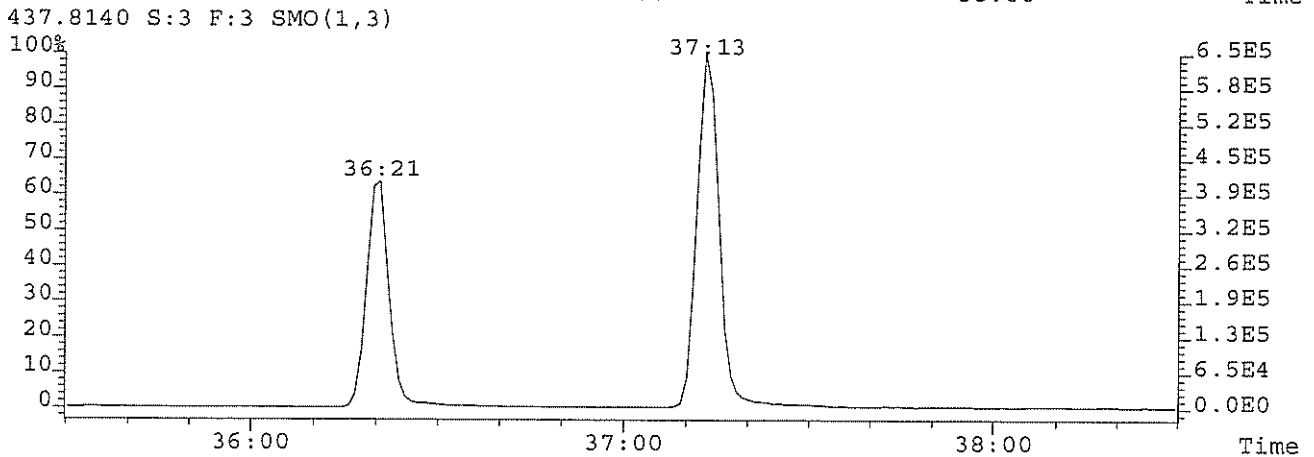
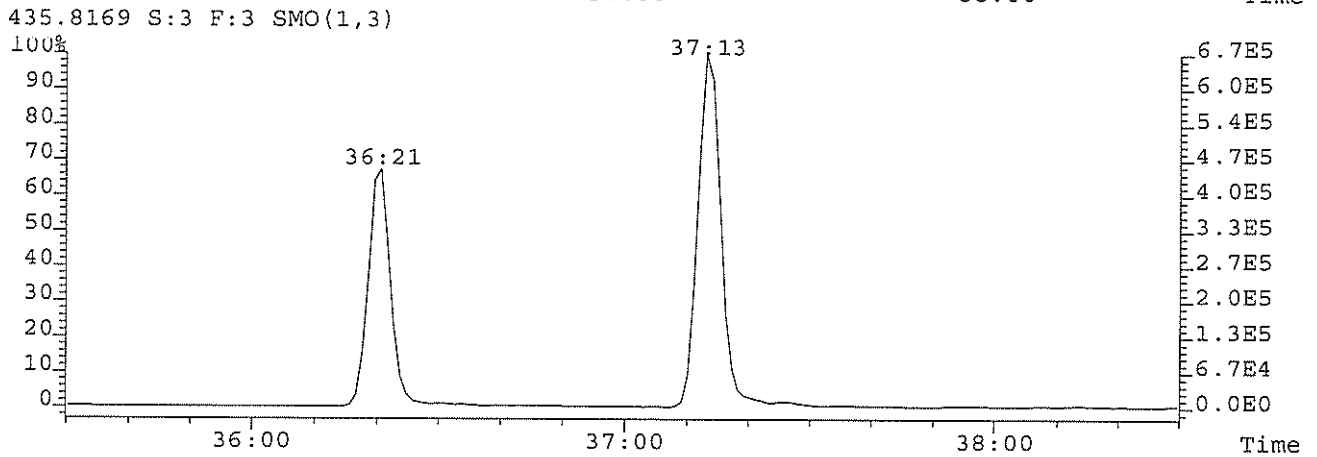
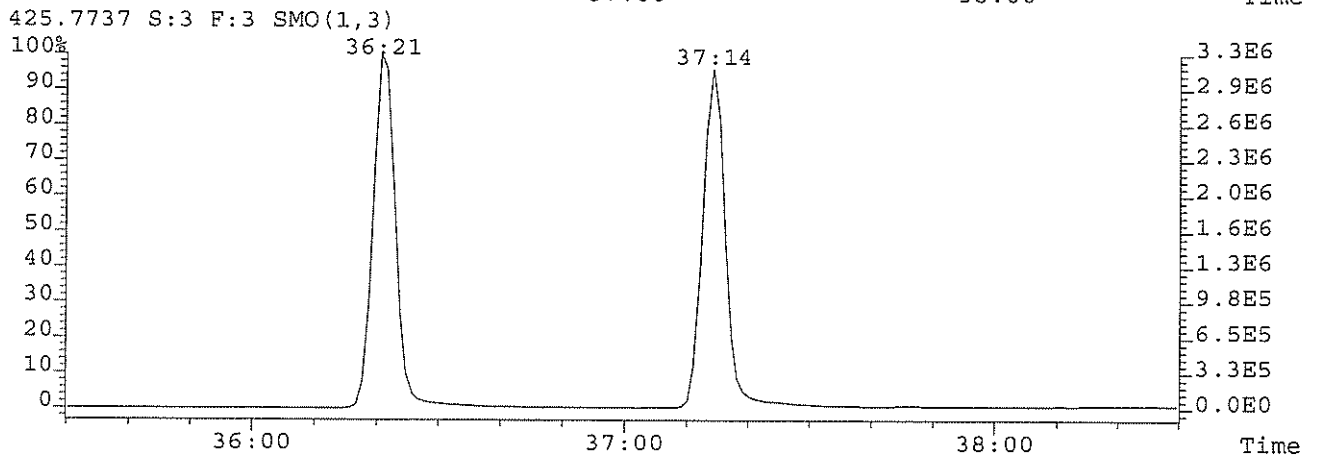
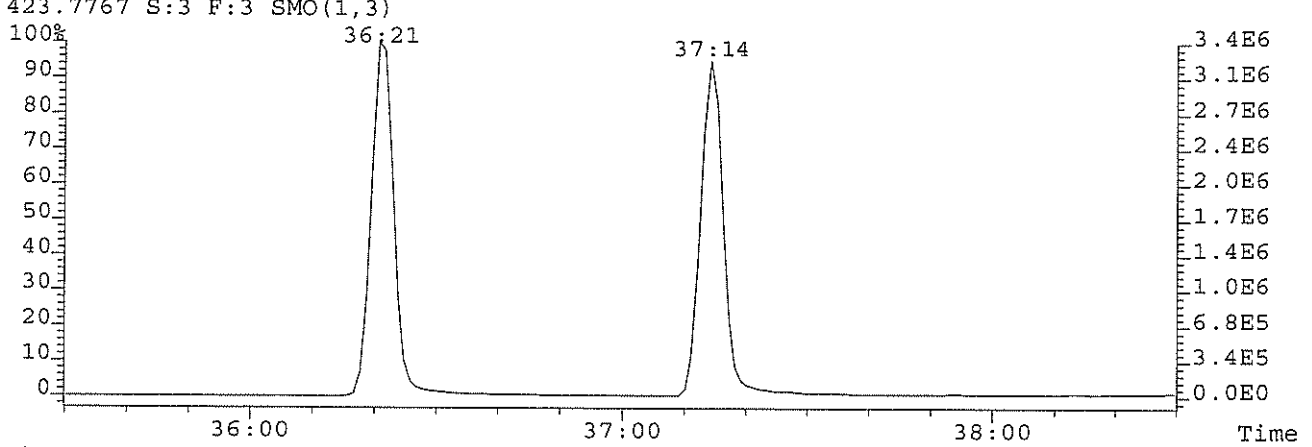
421.8191 S:3 F:3 SMO(1,3)



PCDFsクロマトグラム (9)  
(HpCDFs)

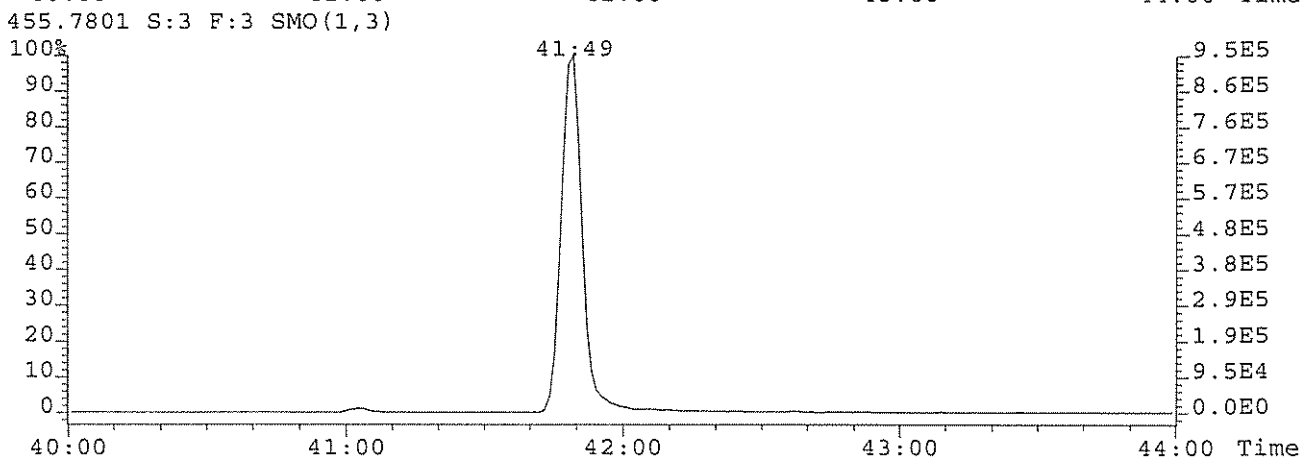
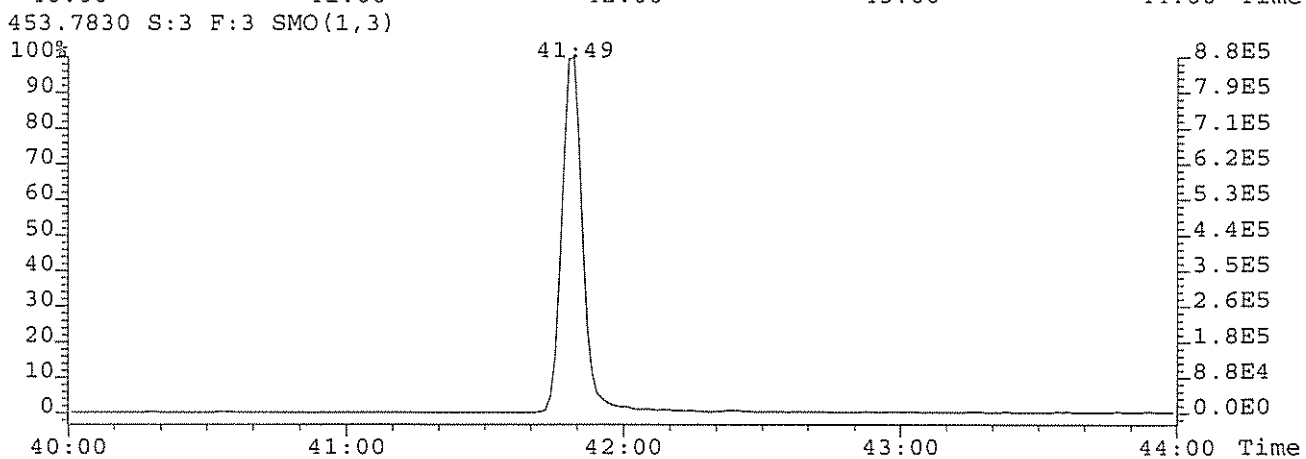
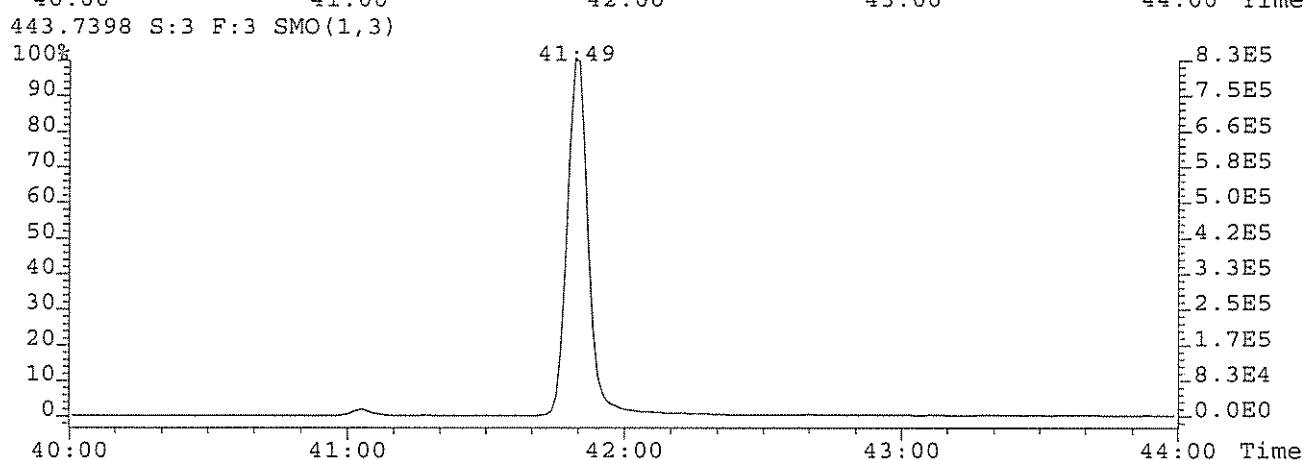
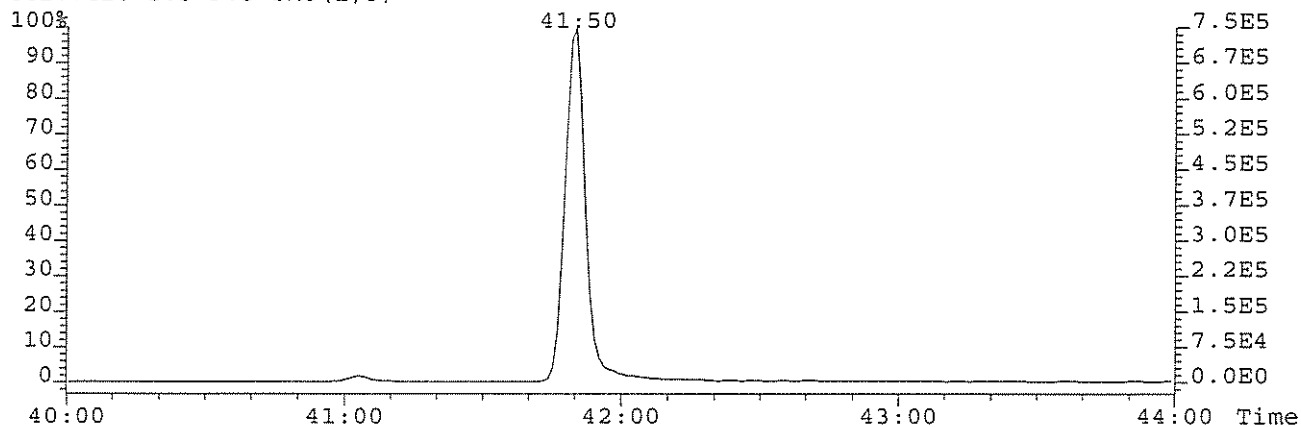


File:130716-2 #1-562 Acq:16-JUL-2013 16:08:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#3 File Text:RH-12ms(5-8,nP) Text:XE13 0947 3 Exp:RH-PD22



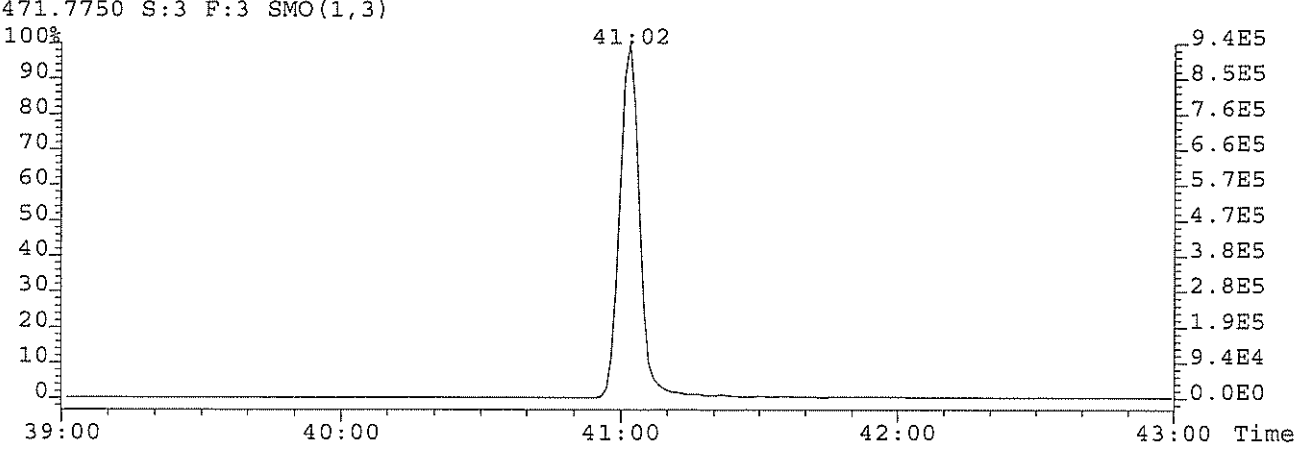
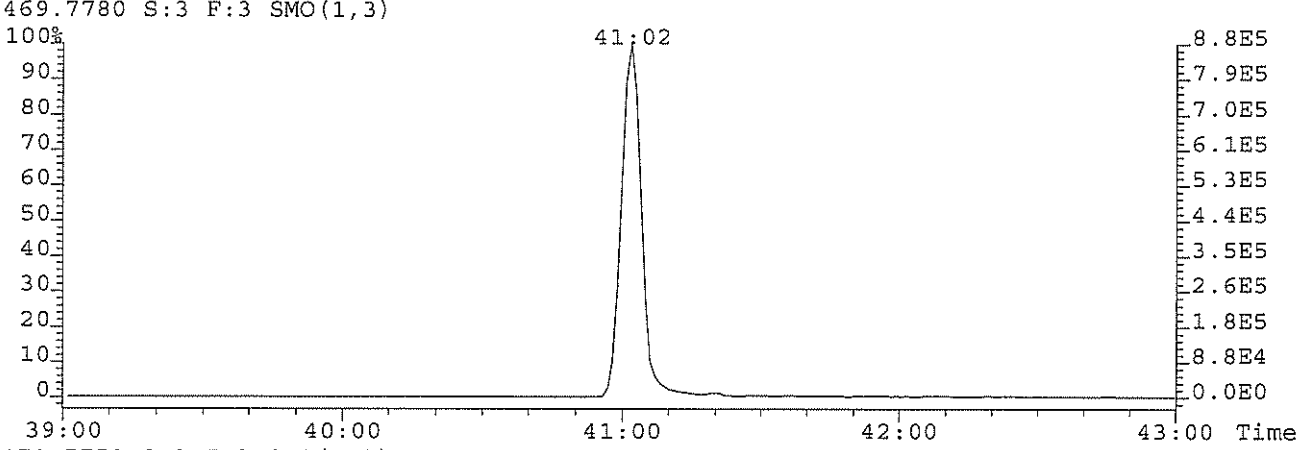
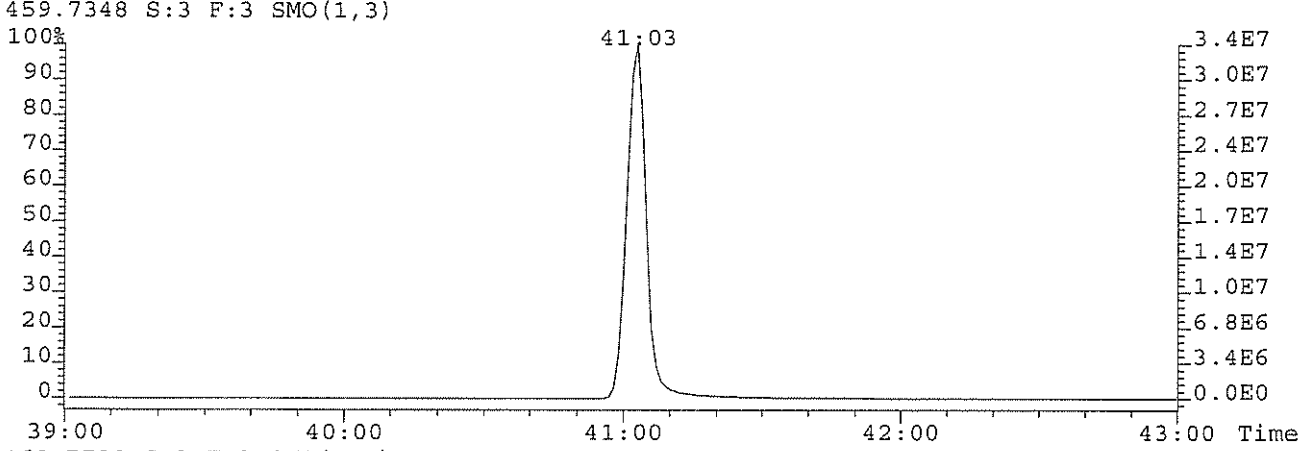
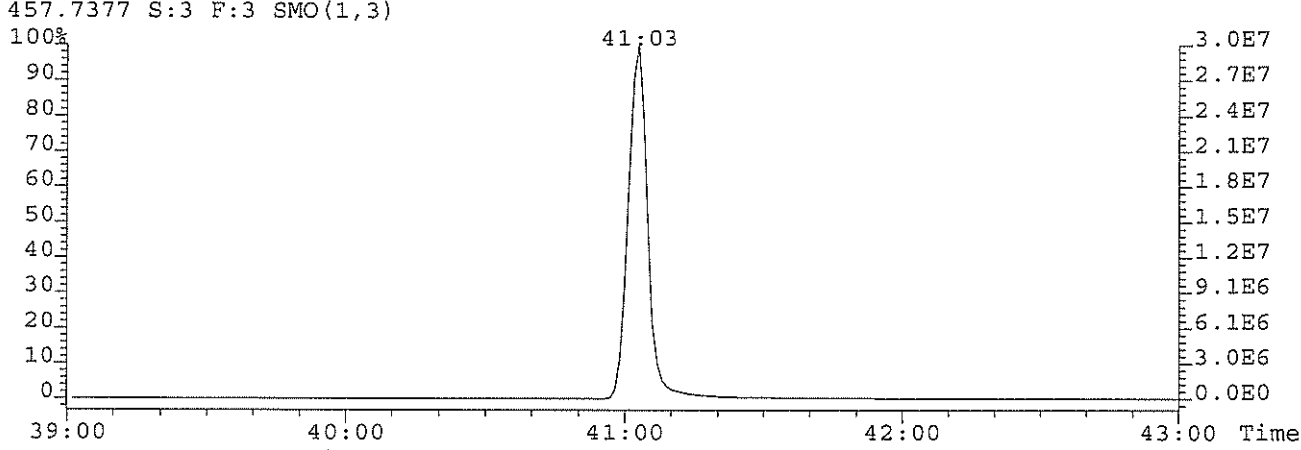
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130716-2 #1-562 Acq:16-JUL-2013 16:08:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#3 File Text:RH-12ms(5-8,nP) Text:XE13 0947 3 Exp:RH-PD22  
441.7428 S:3 F:3 SMO(1,3)



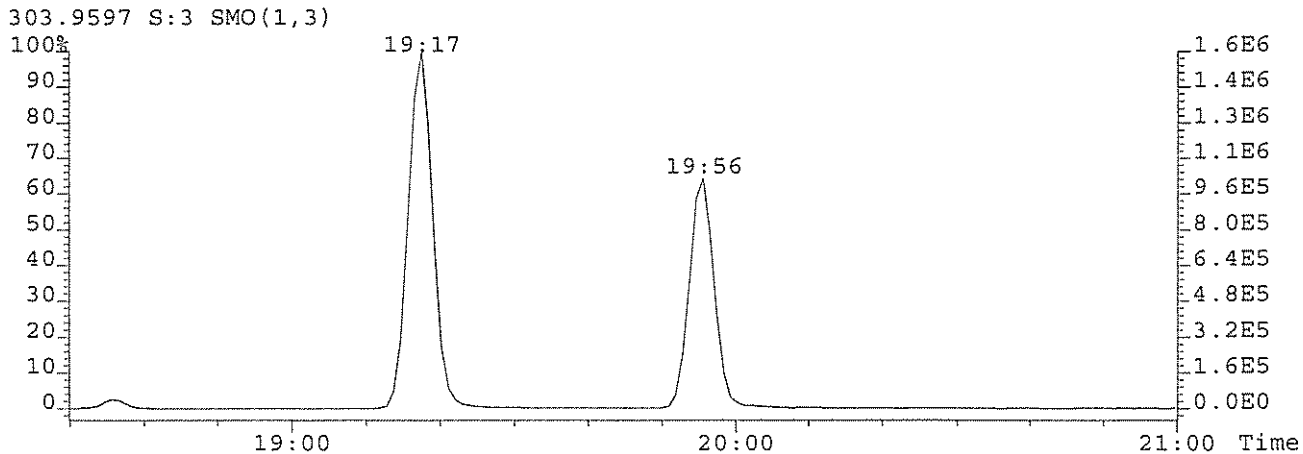
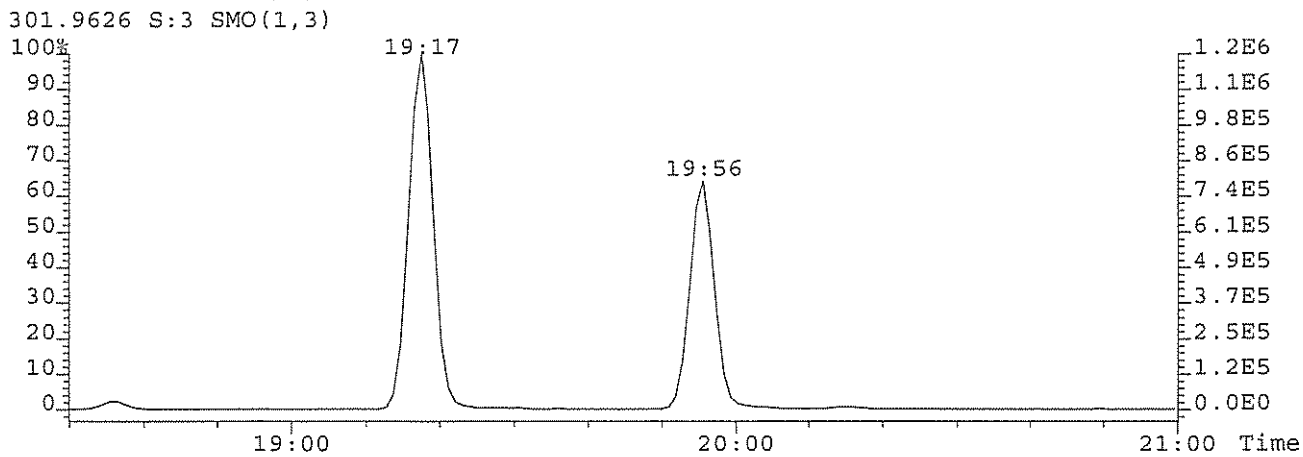
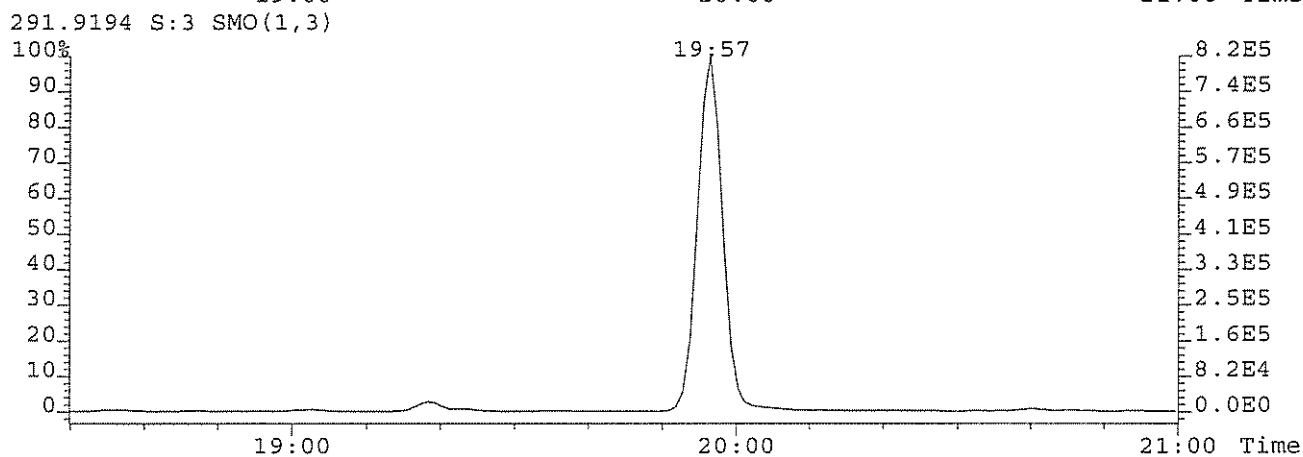
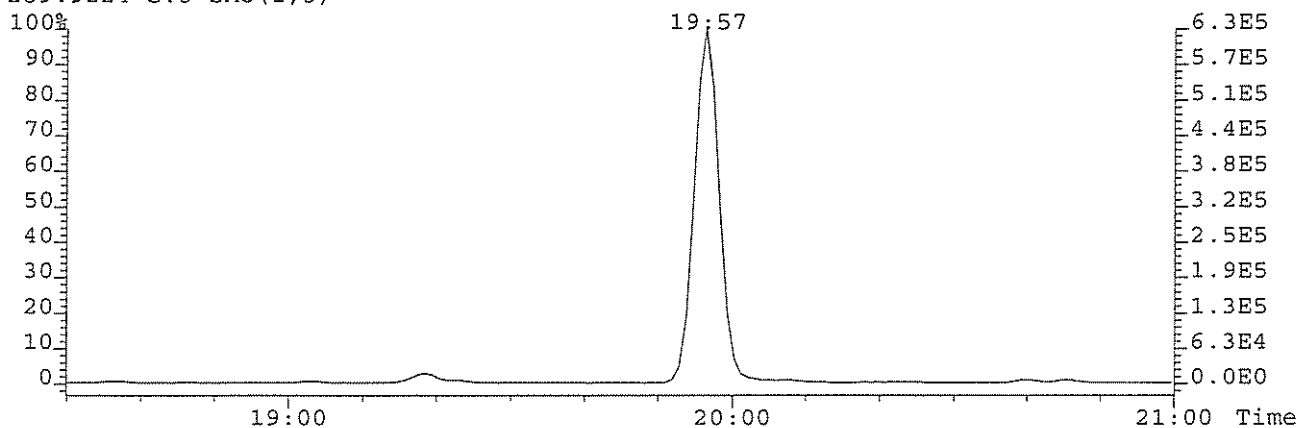
PCDFsクロマトグラム (11)  
(OCDF)

File:130716-2 #1-562 Acq:16-JUL-2013 16:08:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#3 File Text:RH-12ms(5-8,nP) Text:XE13 0947 3 Exp:RH-PD22



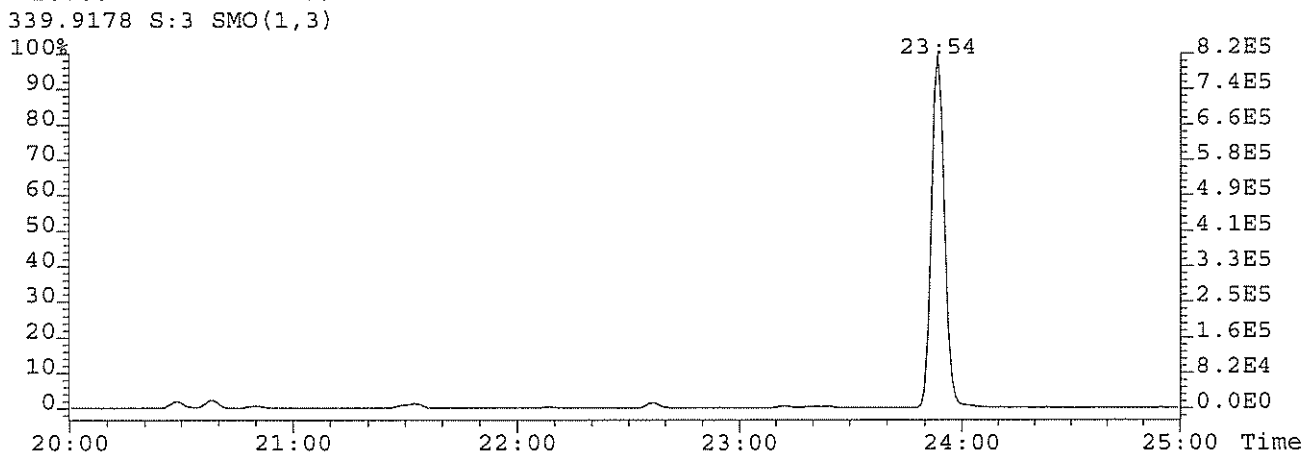
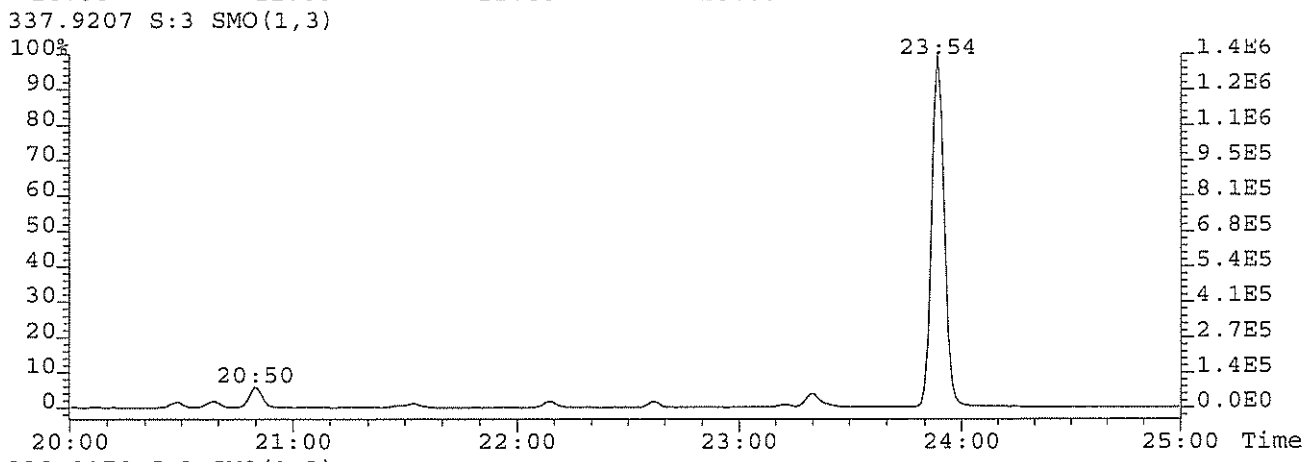
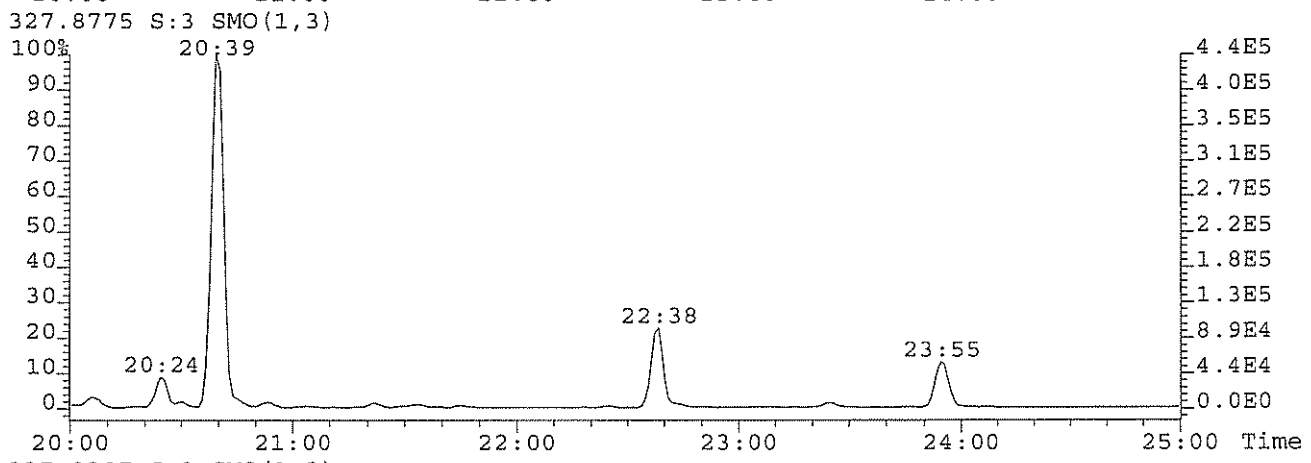
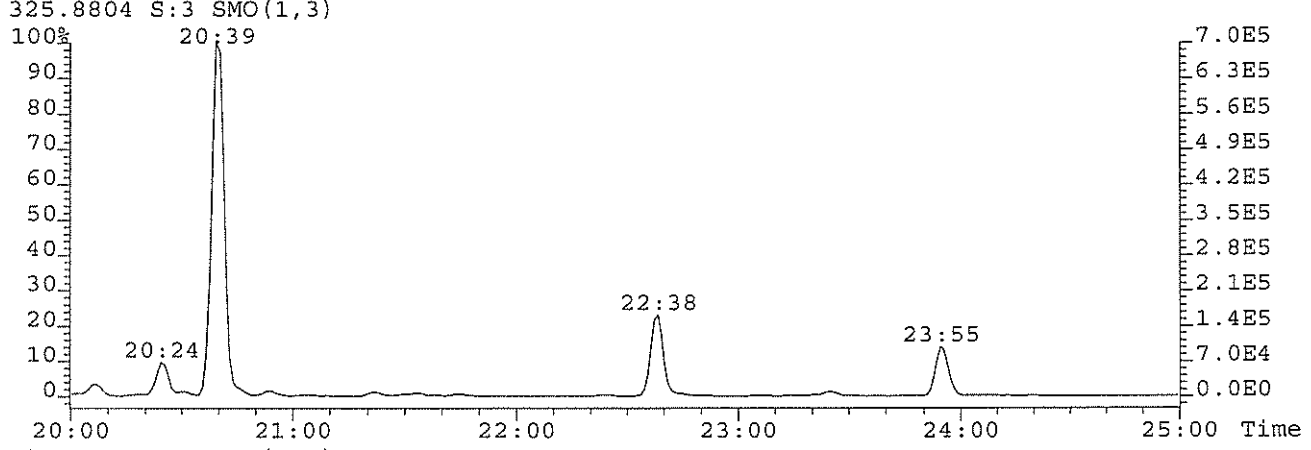
PCDDsクロマトグラム (12)  
(OCDD)

File:130716-2 #1-1430 Acq:16-JUL-2013 16:08:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#3 File Text:RH-12ms(5-8,nP) Text:XE13 0947 3 Exp:RH-PD22  
289.9224 S:3 SMO(1,3)



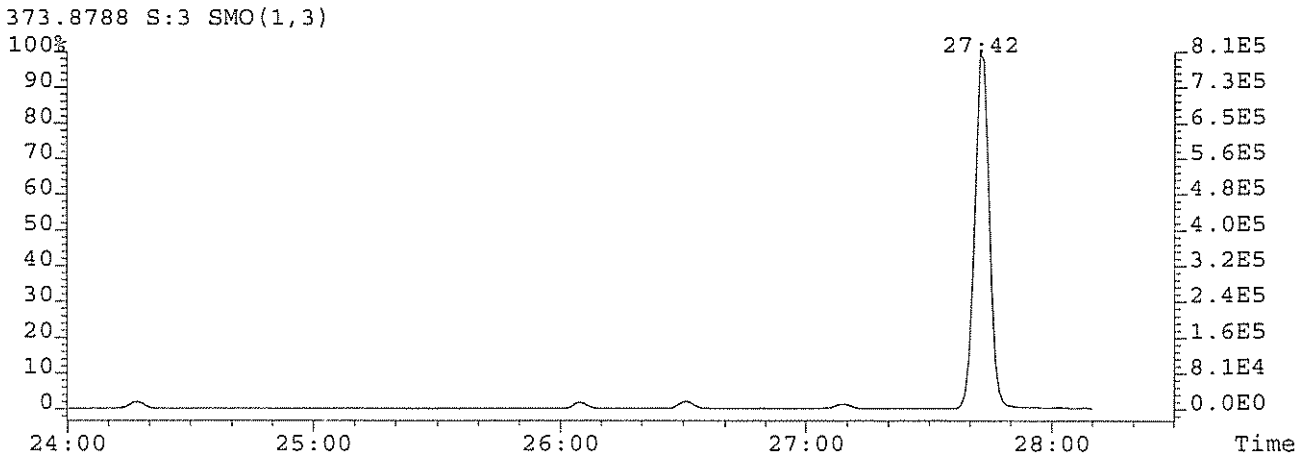
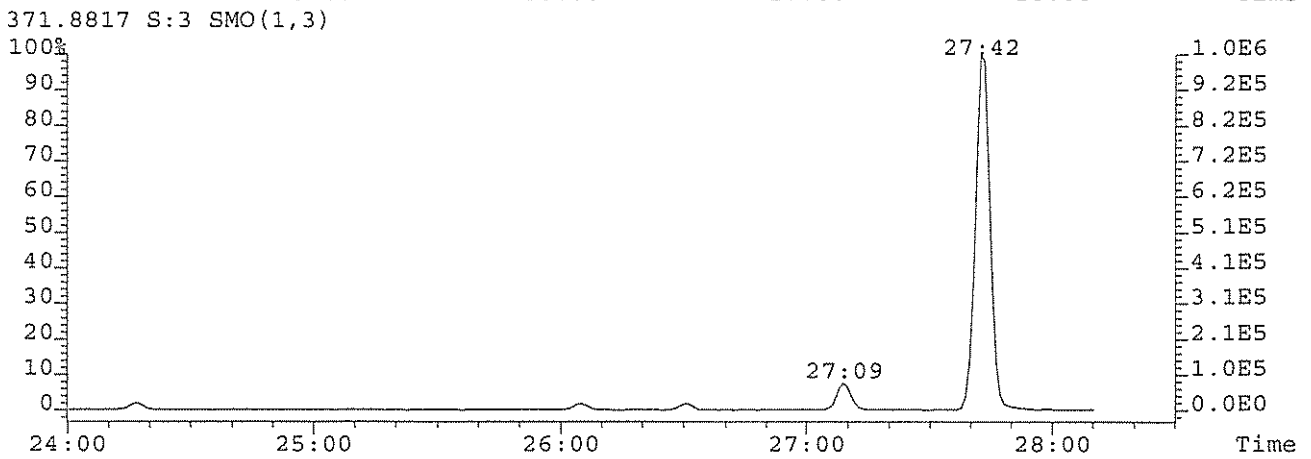
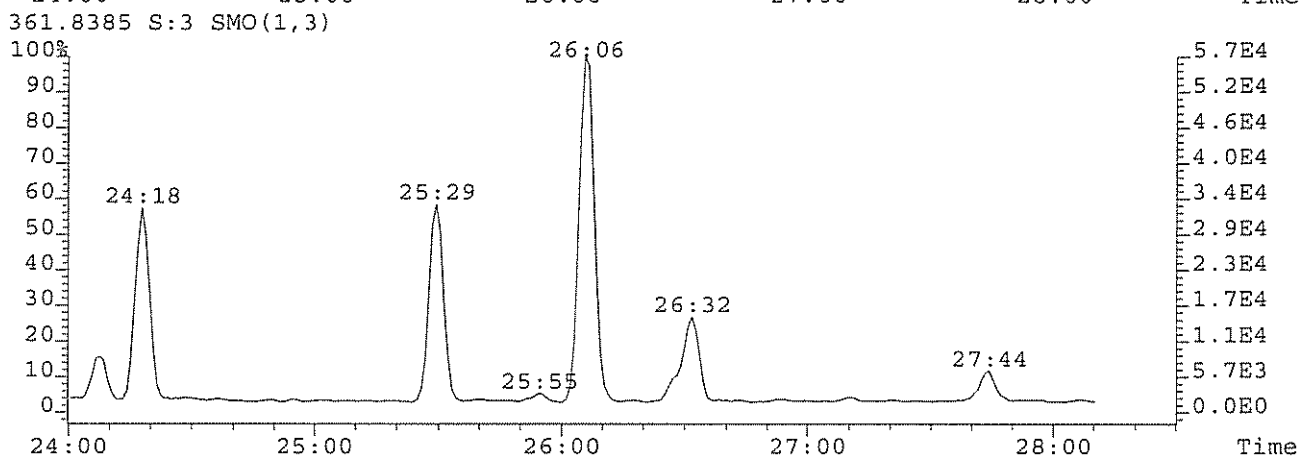
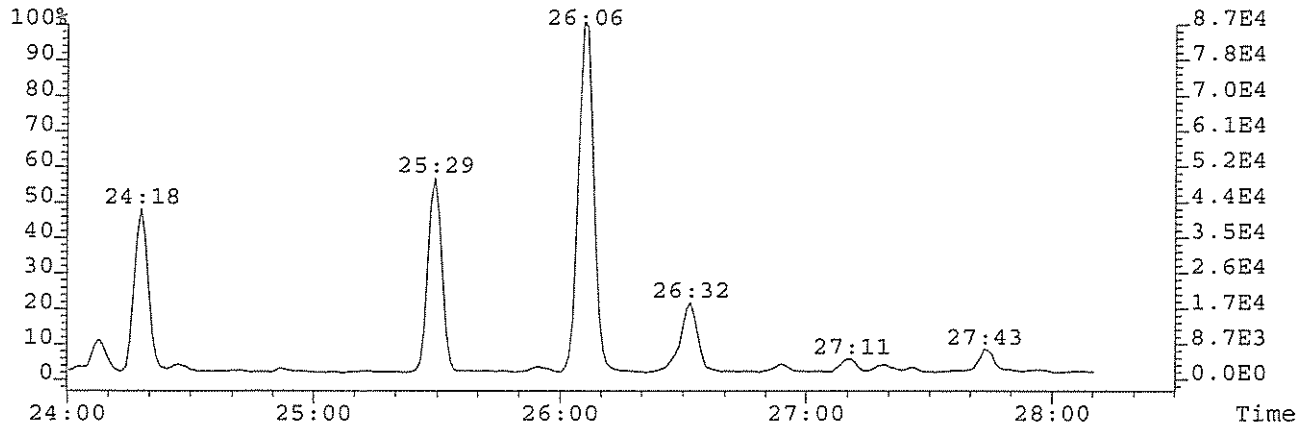
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130716-2 #1-1430 Acq:16-JUL-2013 16:08:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#3 File Text:RH-12ms(5-8,nP) Text:XE13 0947 3 Exp:RH-PD22



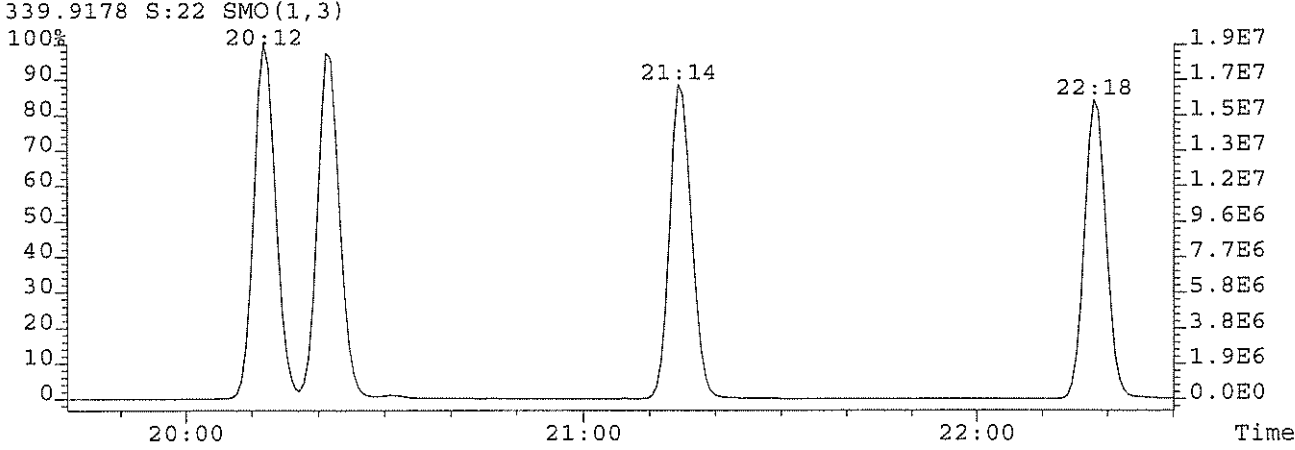
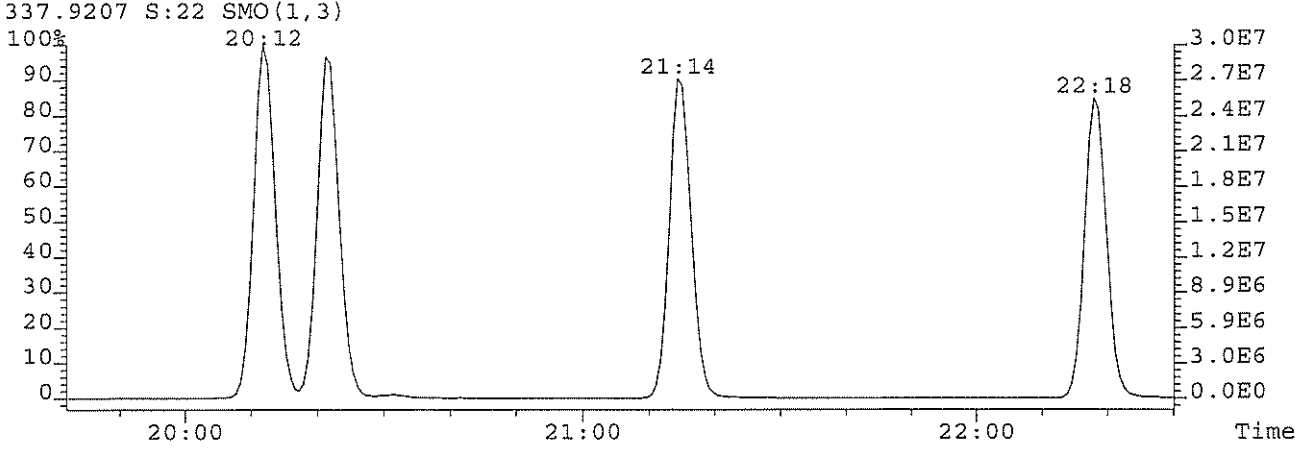
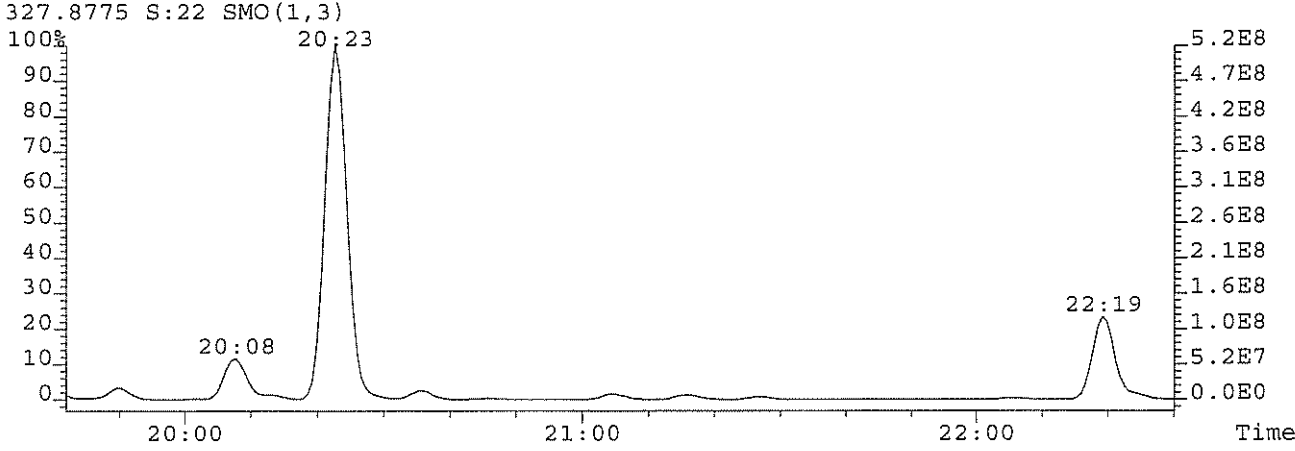
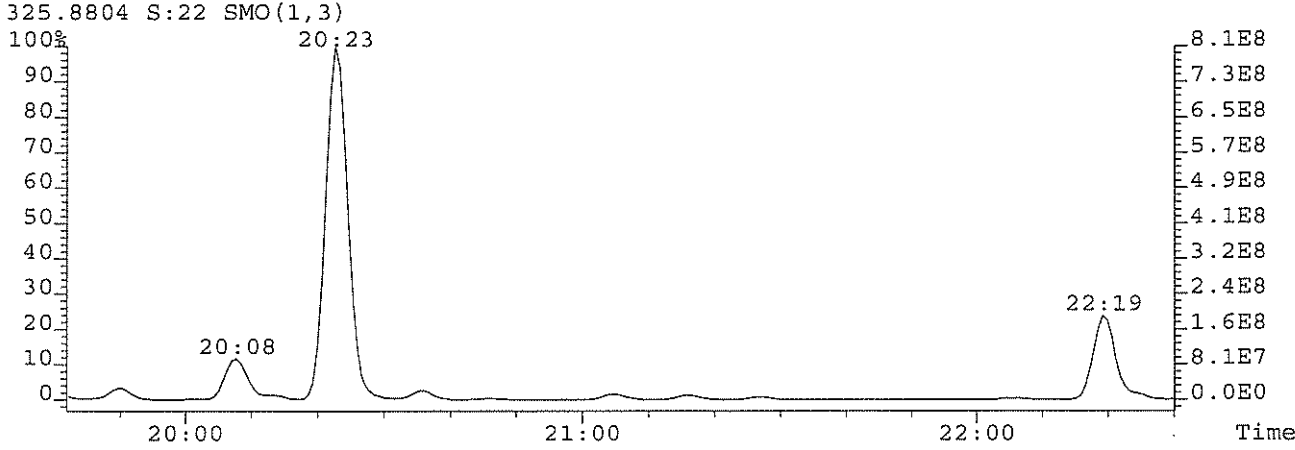
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130716-2 #1-1430 Acq:16-JUL-2013 16:08:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#3 File Text:RH-12ms(5-8,nP) Text:XE13 0947 3 Exp:RH-PD22  
359.8415 S:3 SMO(1,3)



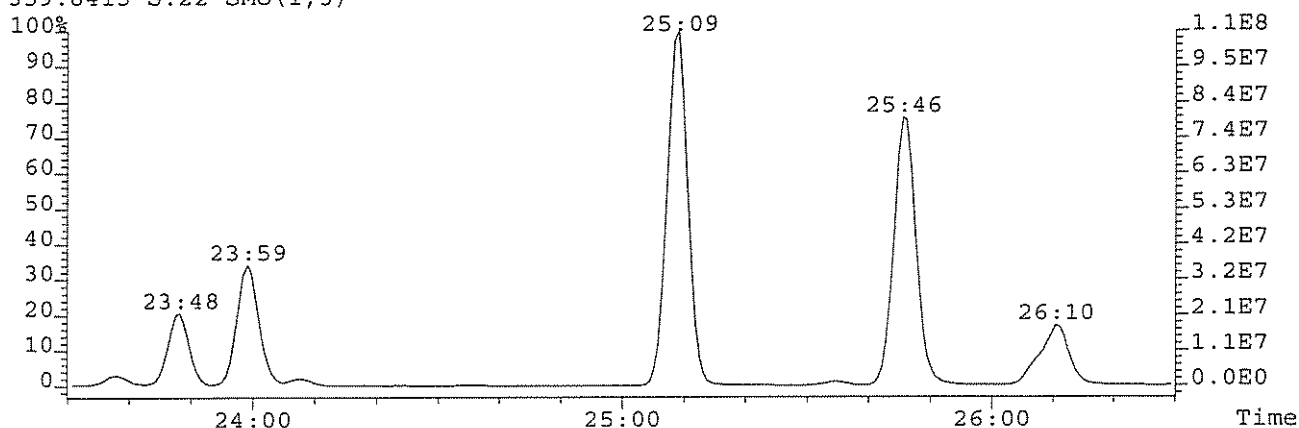
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130711-2 #1-2899 Acq:12-JUL-2013 08:48:10 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(mP) Text:XE13 0947 2 Exp:RH-MP11

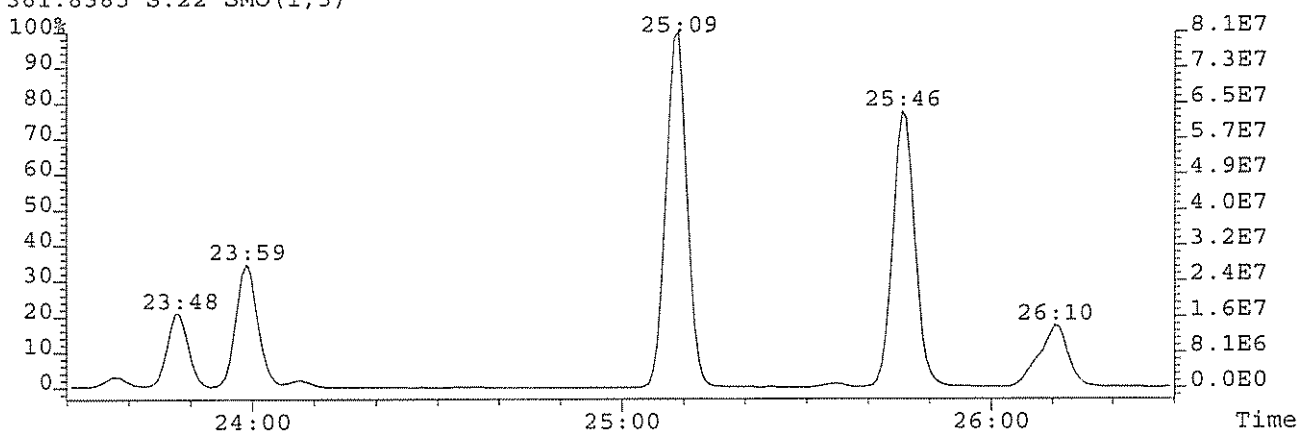


DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

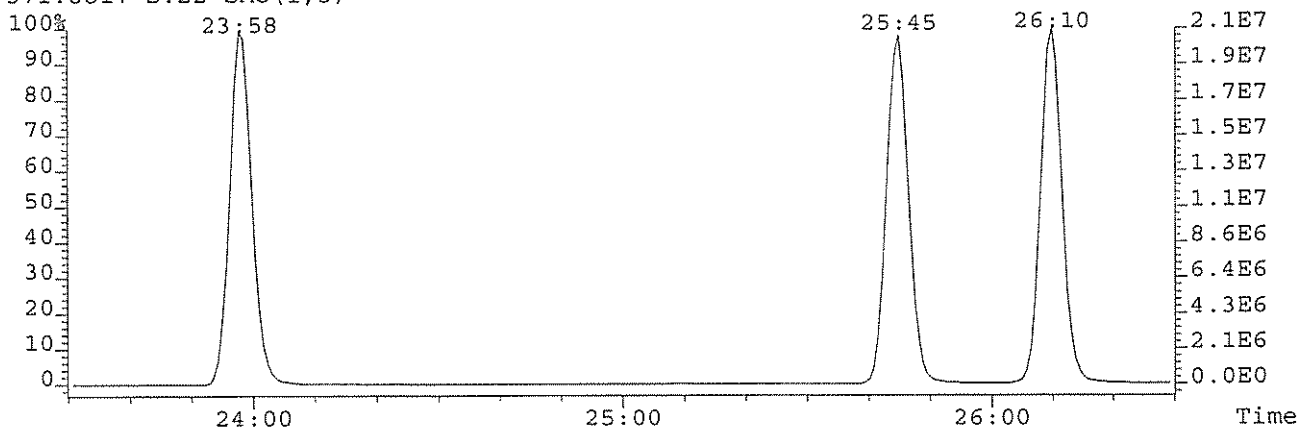
File:130711-2 #1-2899 Acq:12-JUL-2013 08:48:10 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(mP) Text:XE13 0947 2 Exp:RH-MP11  
359.8415 S:22 SMO(1,3)



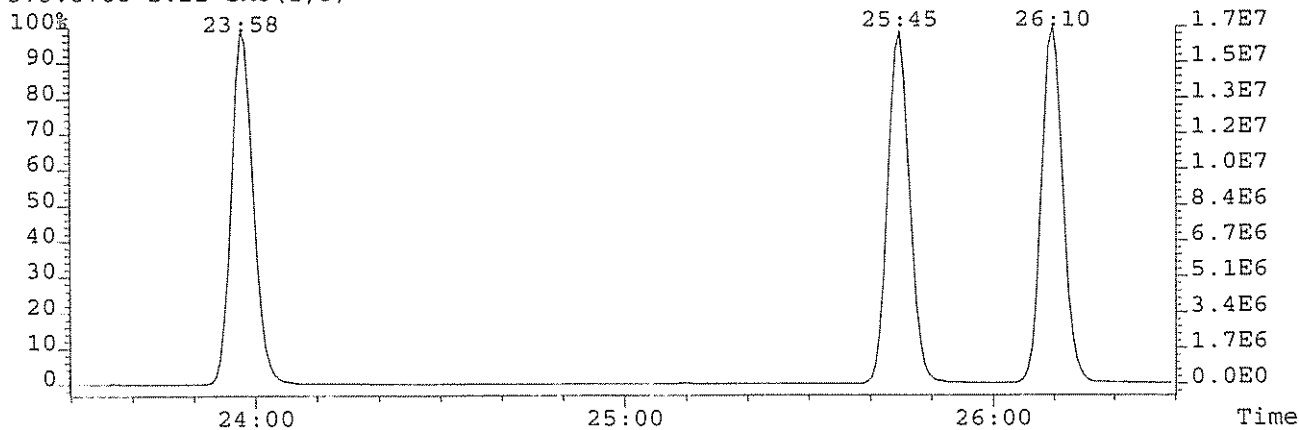
361.8385 S:22 SMO(1,3)



371.8817 S:22 SMO(1,3)



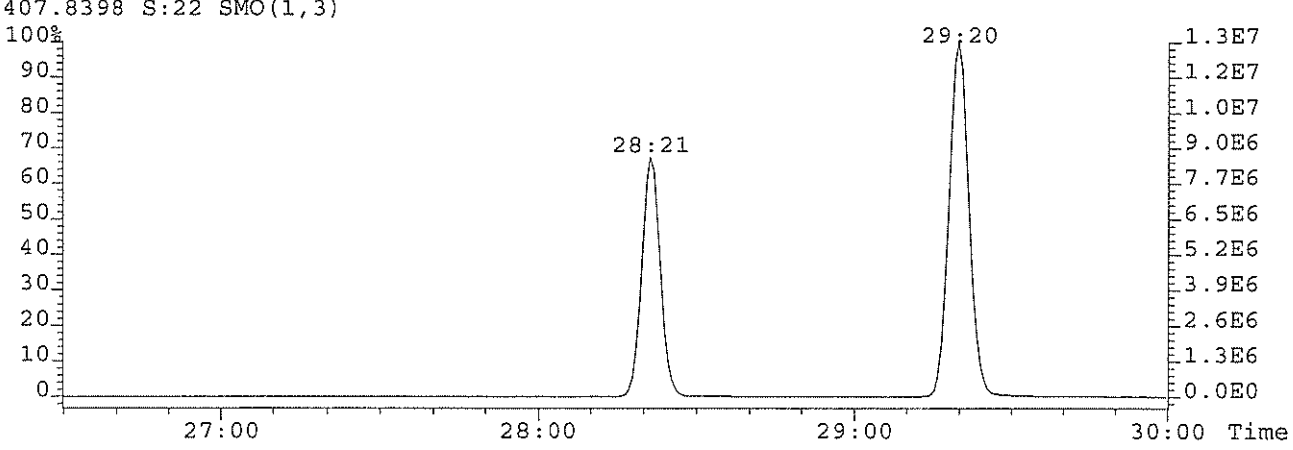
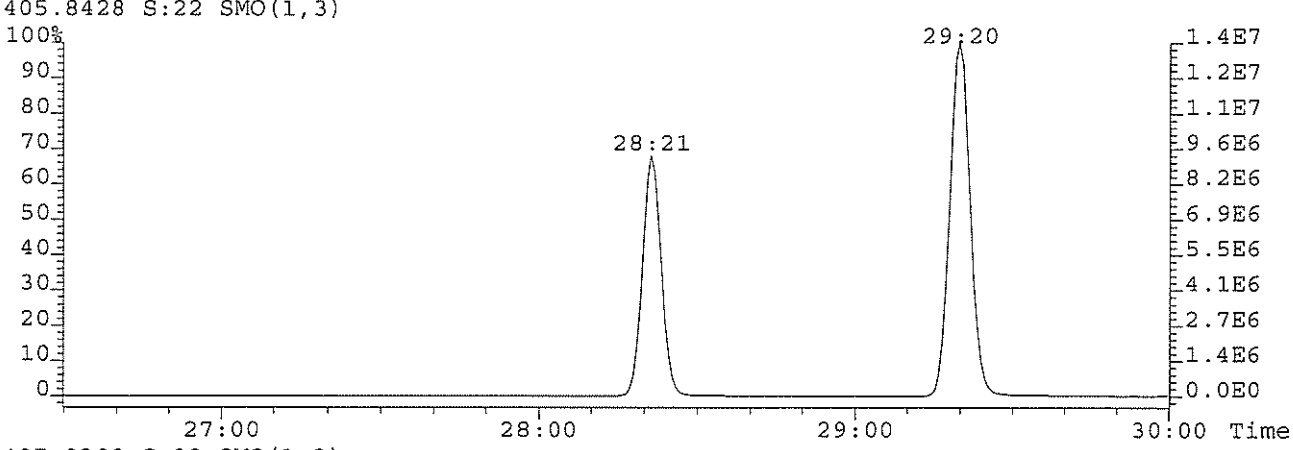
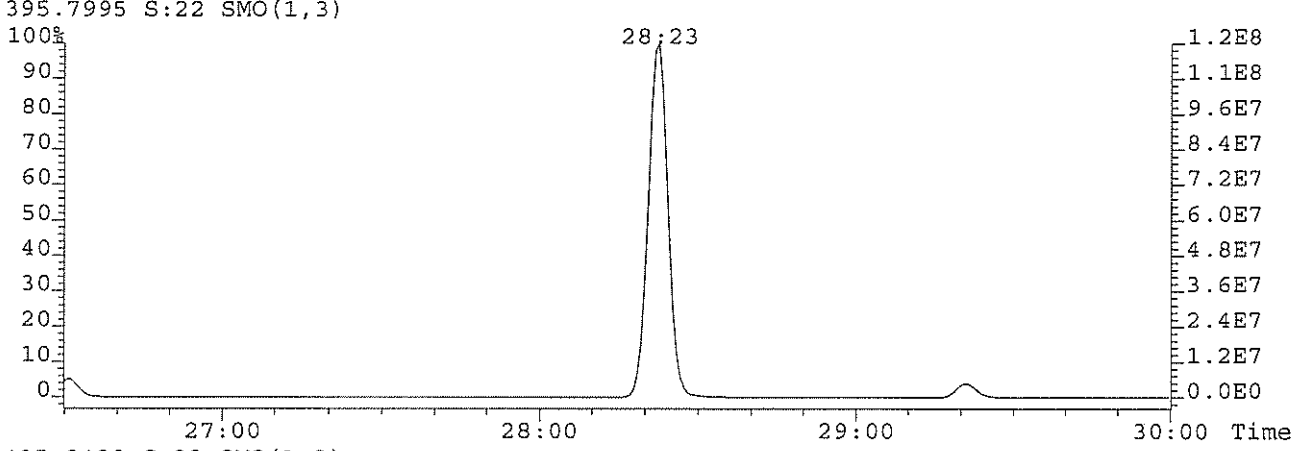
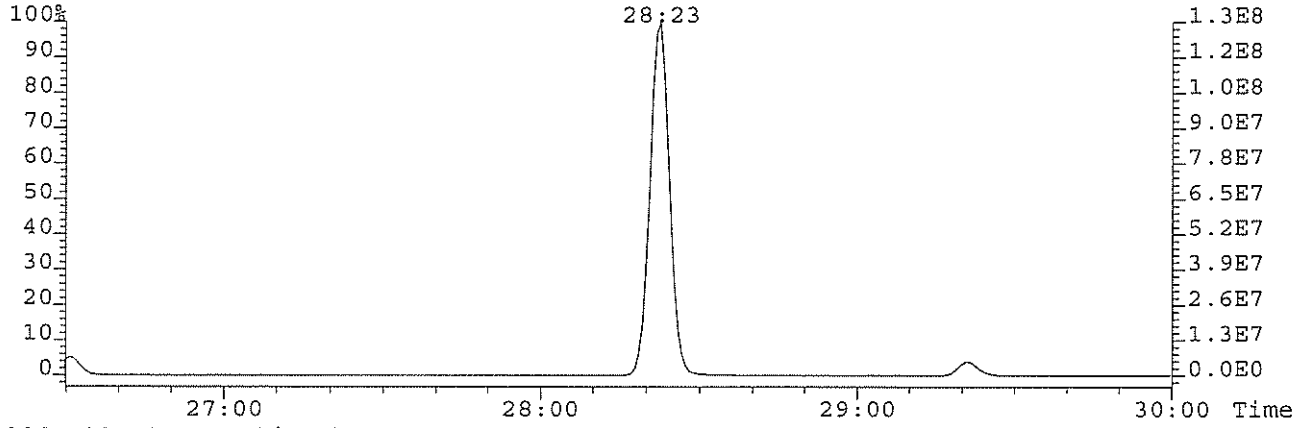
373.8788 S:22 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)



File:130711-2 #1-2899 Acq:12-JUL-2013 08:48:10 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(mP) Text:XEL3 0947 2 Exp:RH-MP11  
393.8025 S:22 SMO(1,3)

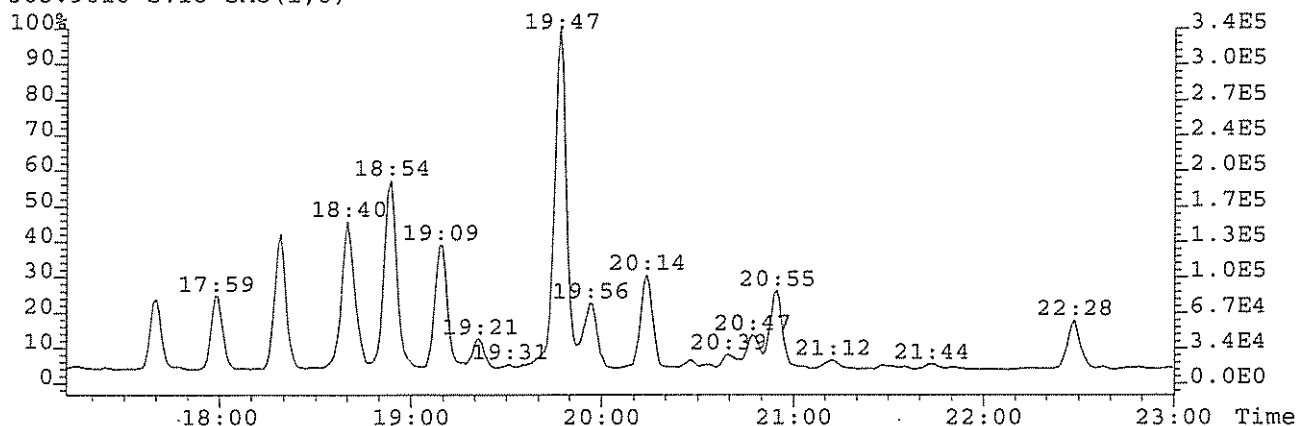


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

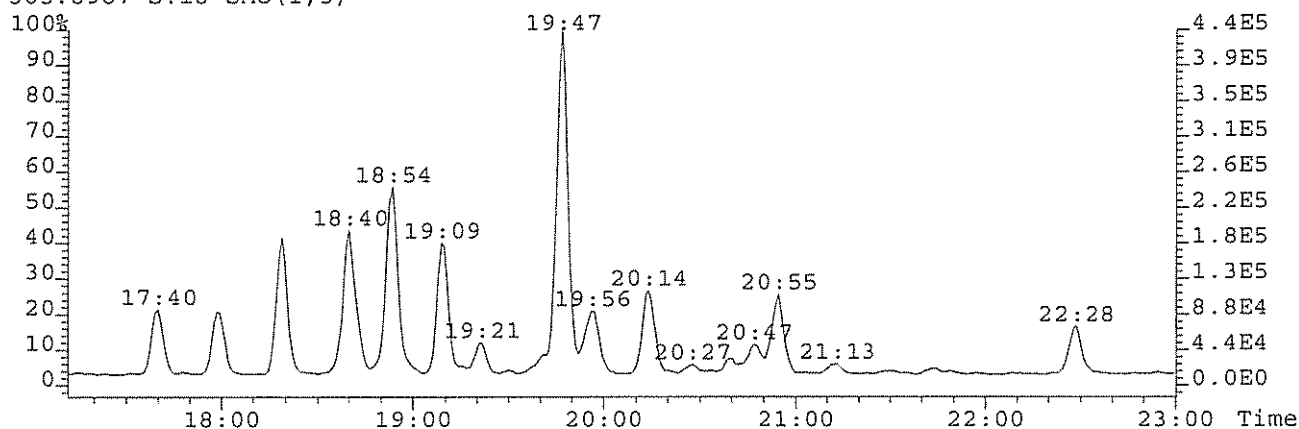
試料管理番号	XE 130948
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.2

File:130710-2 #1-1578 Acq:11-JUL-2013 05:04:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:BPX-DXN(4-6DXN) Text:XE13 0948 Exp:BPX04

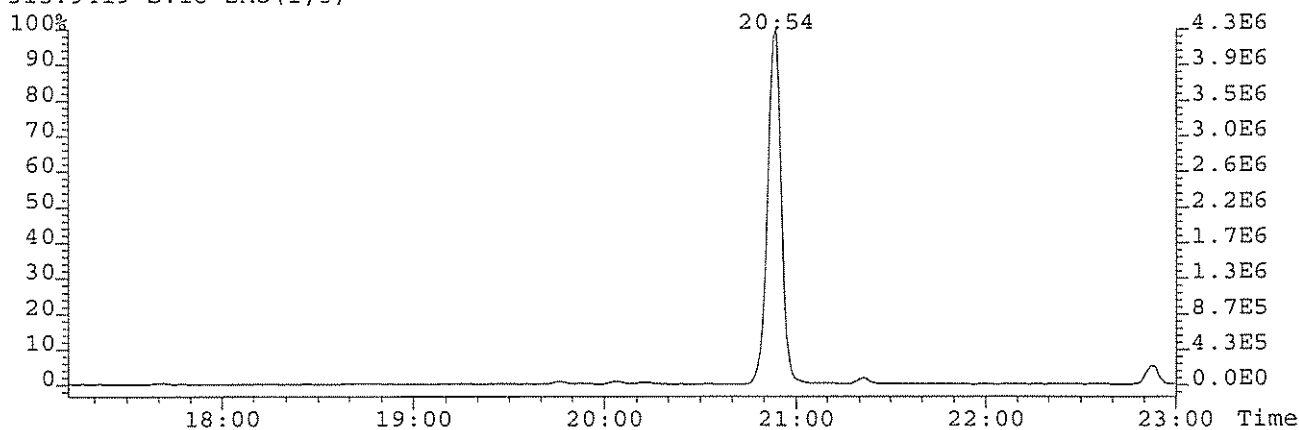
303.9016 S:18 SMO(1,3)



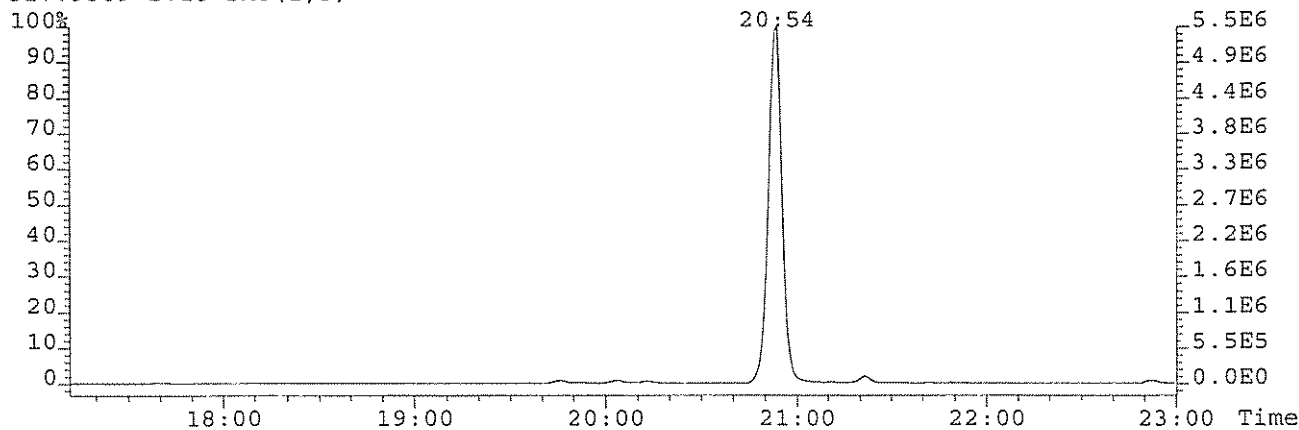
305.8987 S:18 SMO(1,3)



315.9419 S:18 SMO(1,3)

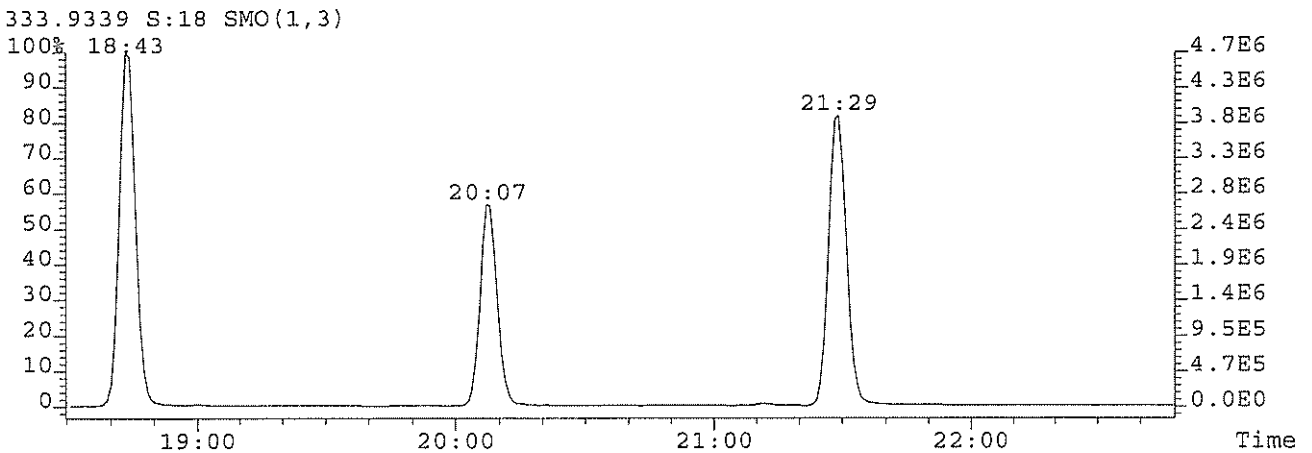
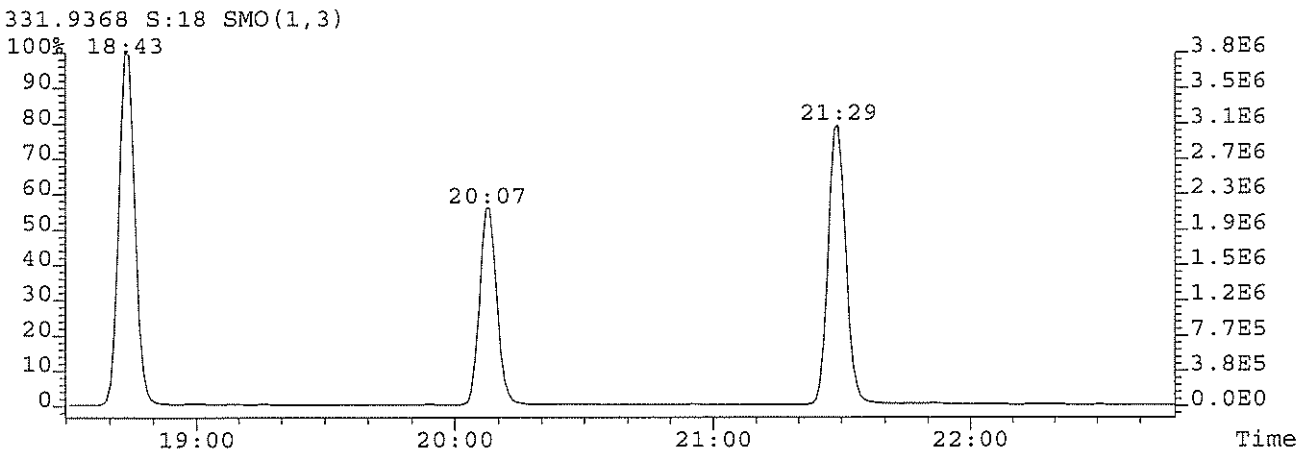
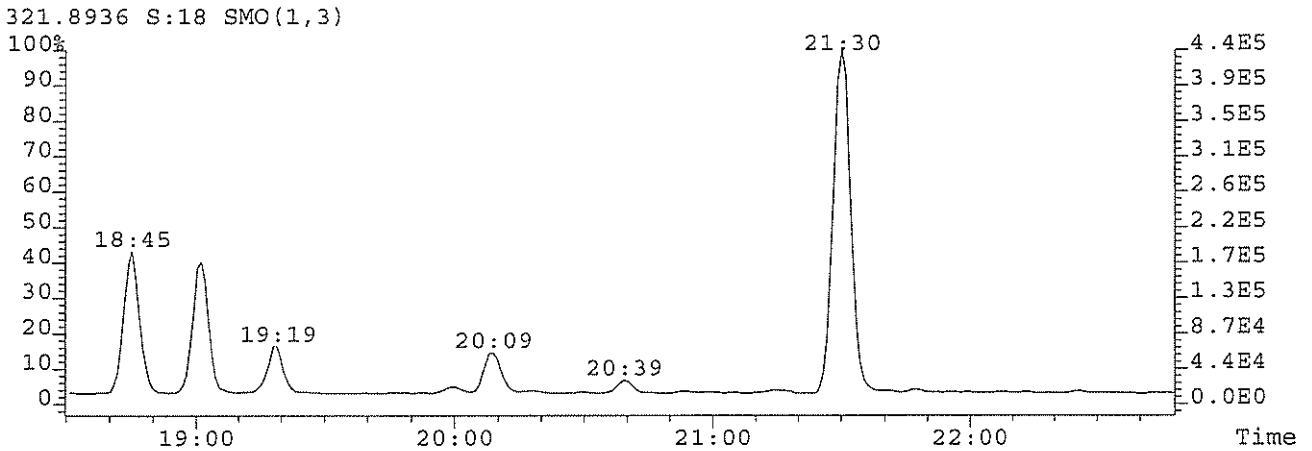
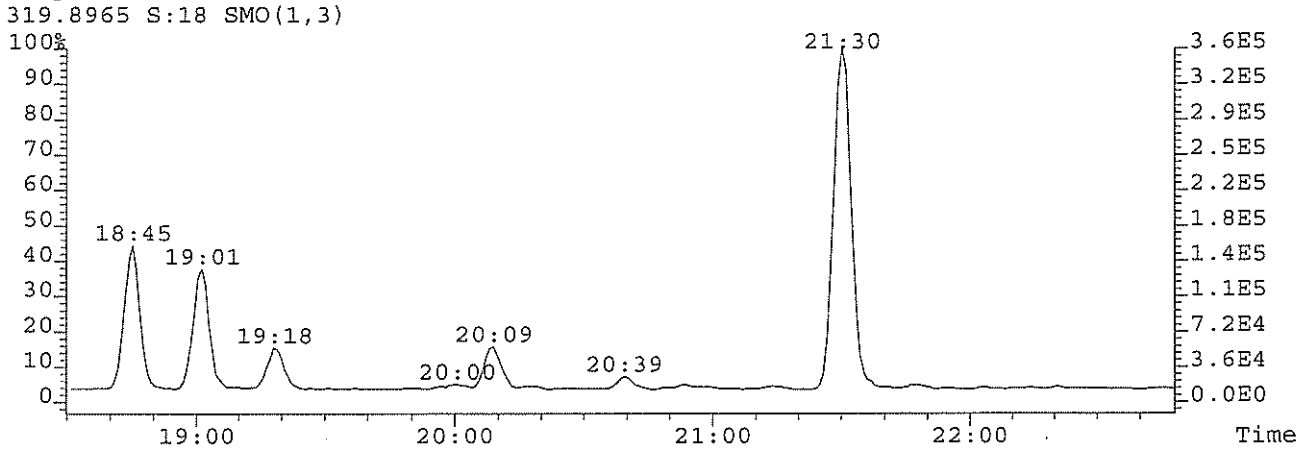


317.9389 S:18 SMO(1,3)



PCDFsクロマトグラム (1)  
(TeCDFs)

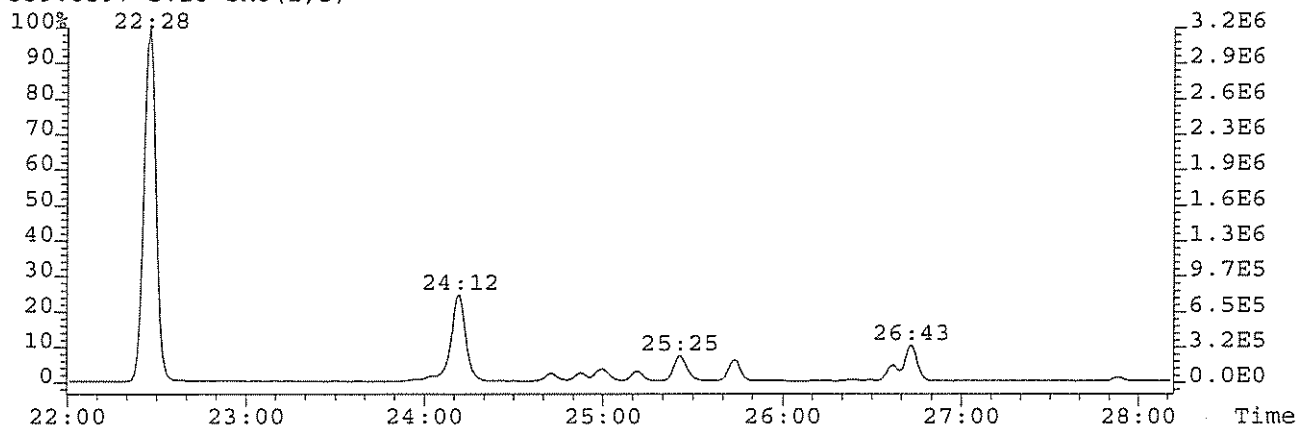
File:130710-2 #1-1578 Acq:11-JUL-2013 05:04:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:BPX-DXN(4-6DXN) Text:XE13 0948 Exp:BPX04



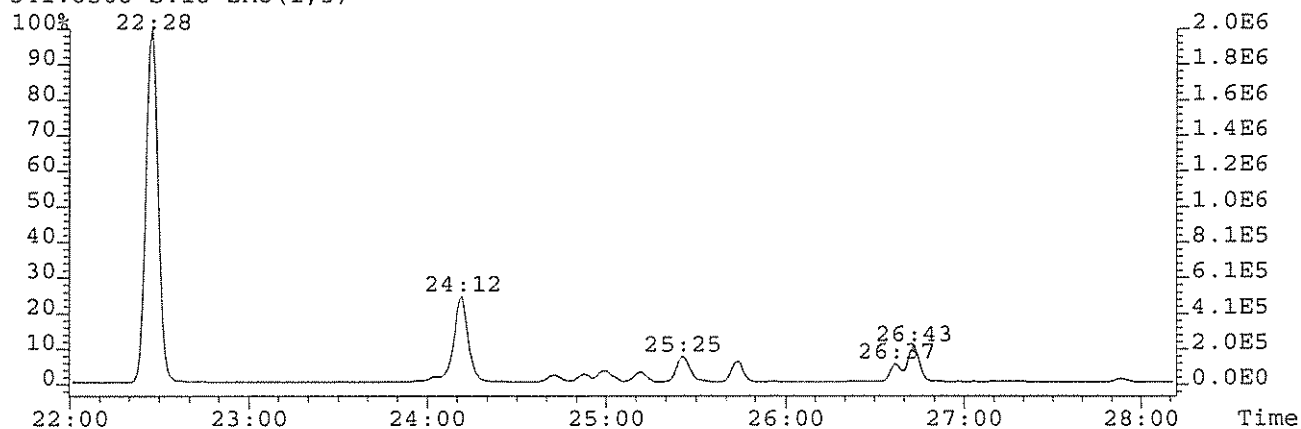
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130710-2 #1-1578 Acq:11-JUL-2013 05:04:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:BPX-DXN(4-6DXN) Text:XE13 0948 Exp:BPX04

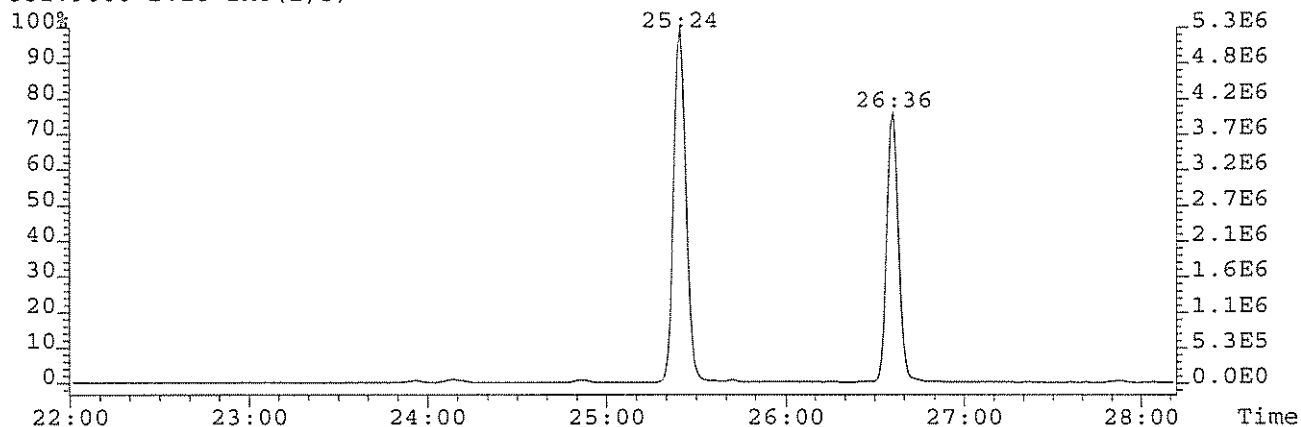
339.8597 S:18 SMO(1,3)



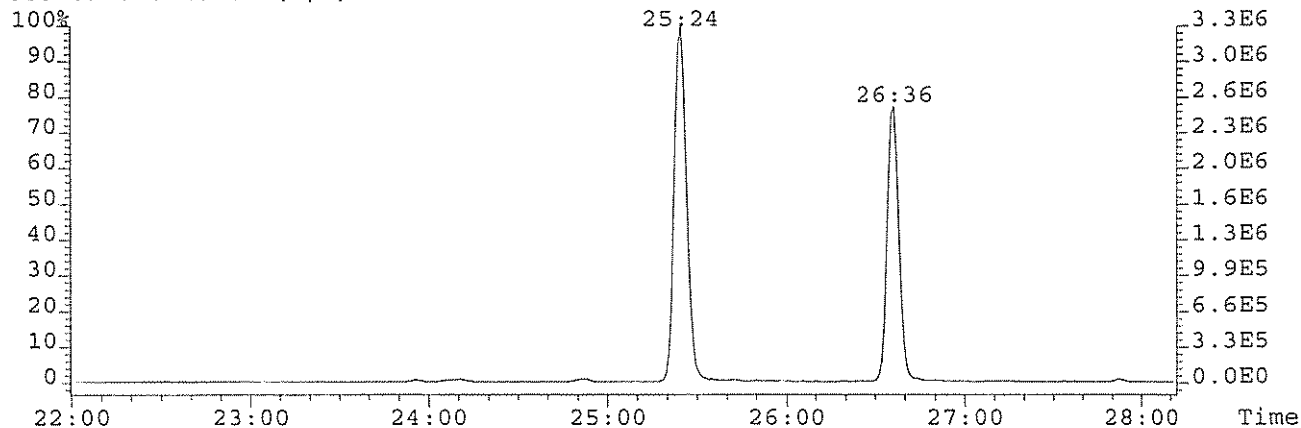
341.8568 S:18 SMO(1,3)



351.9000 S:18 SMO(1,3)

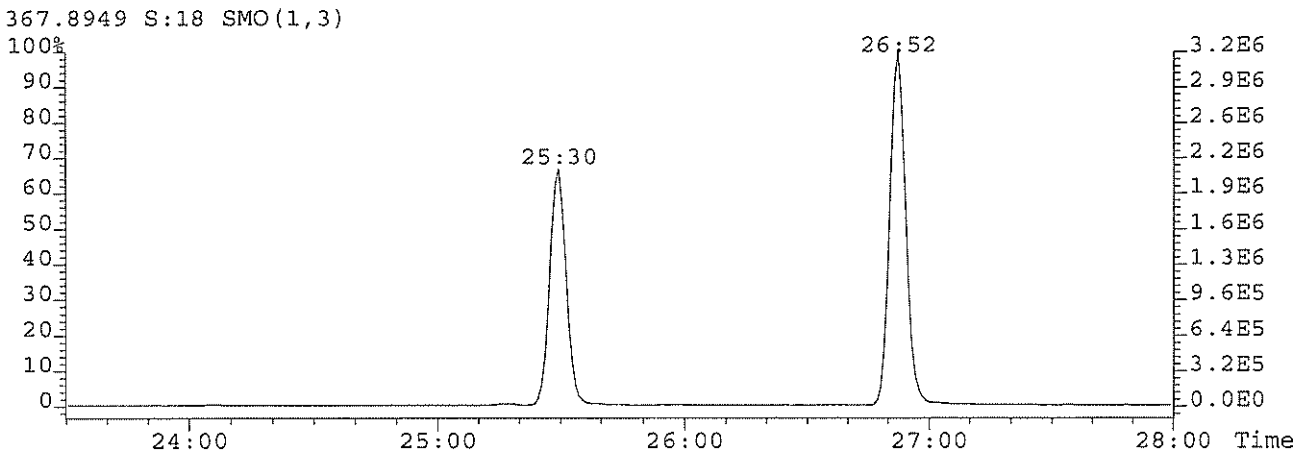
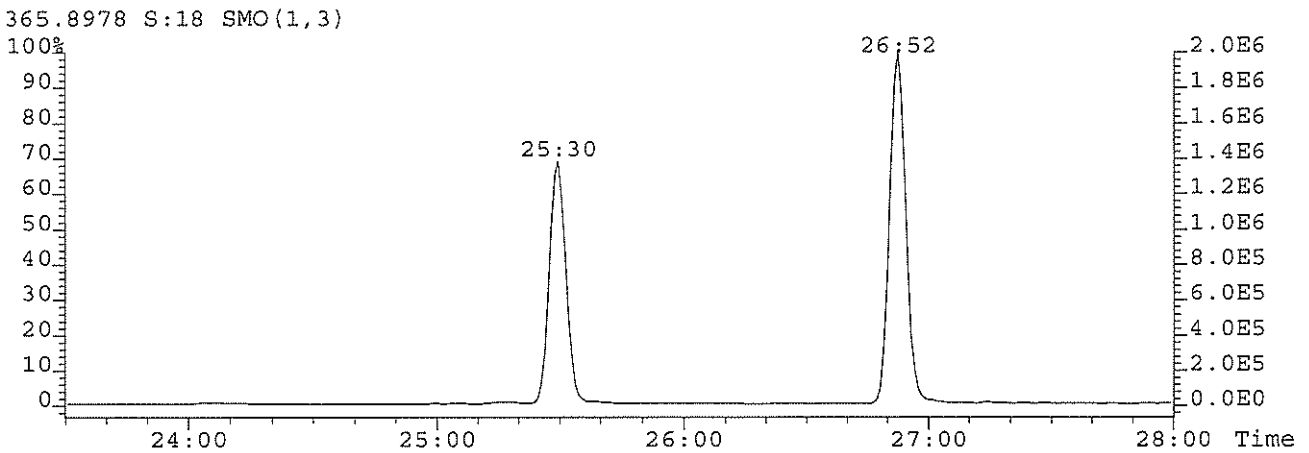
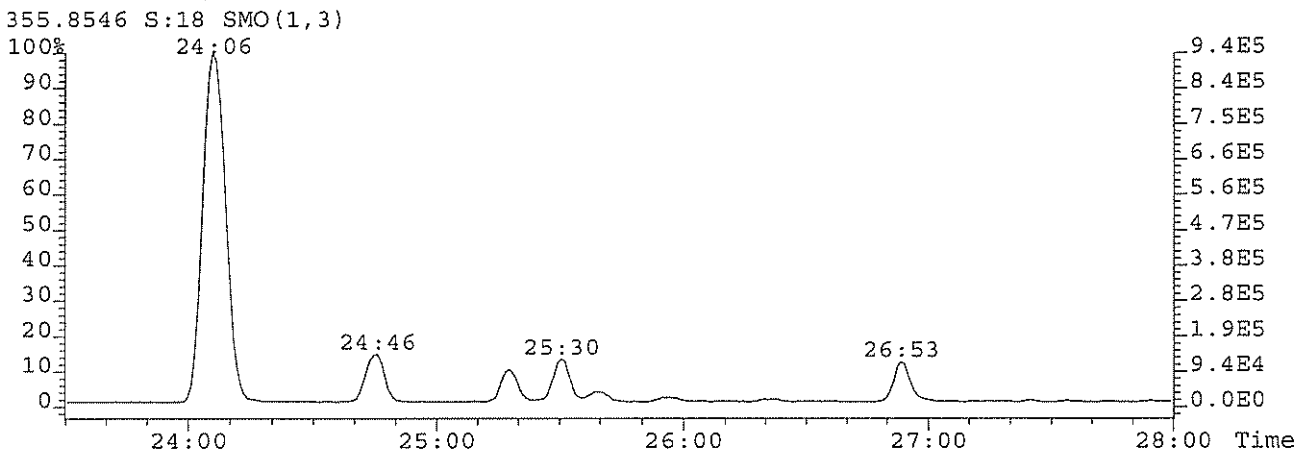
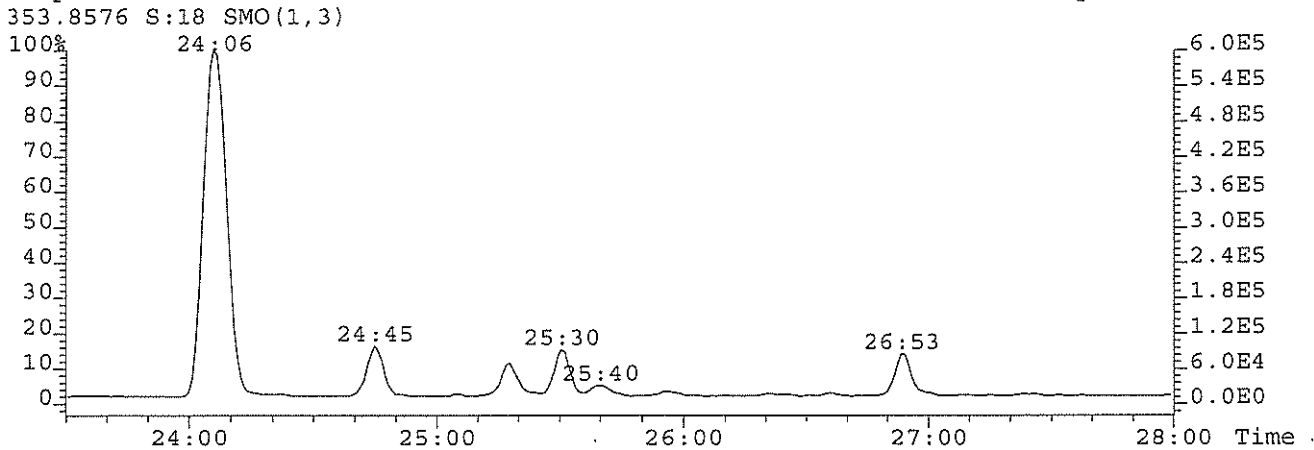


353.8970 S:18 SMO(1,3)



PCDFsクロマトグラム (3)  
(PeCDFs)

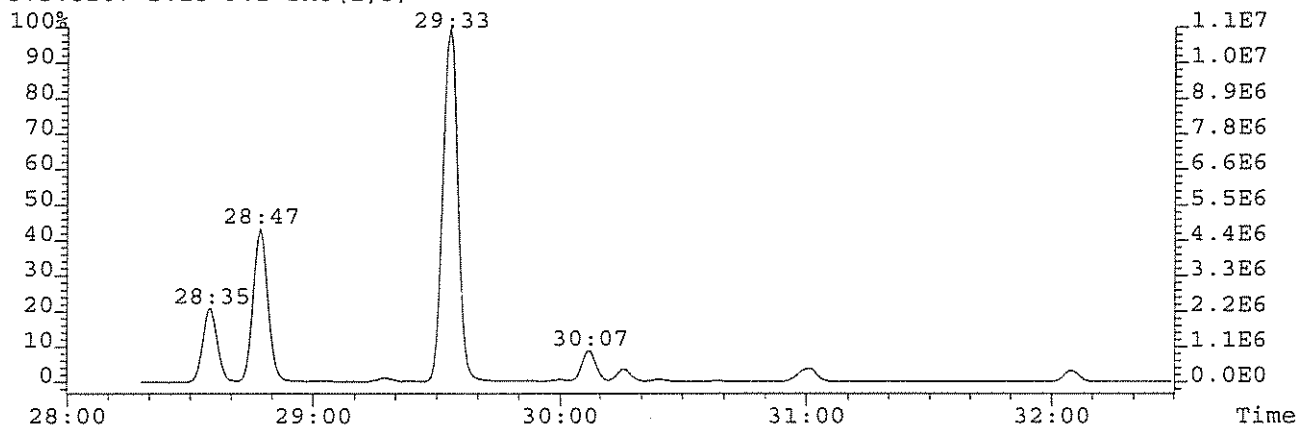
File:130710-2 #1-1578 Acq:11-JUL-2013 05:04:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:BPX-DXN(4-6DXN) Text:XE13 0948 Exp:BPX04



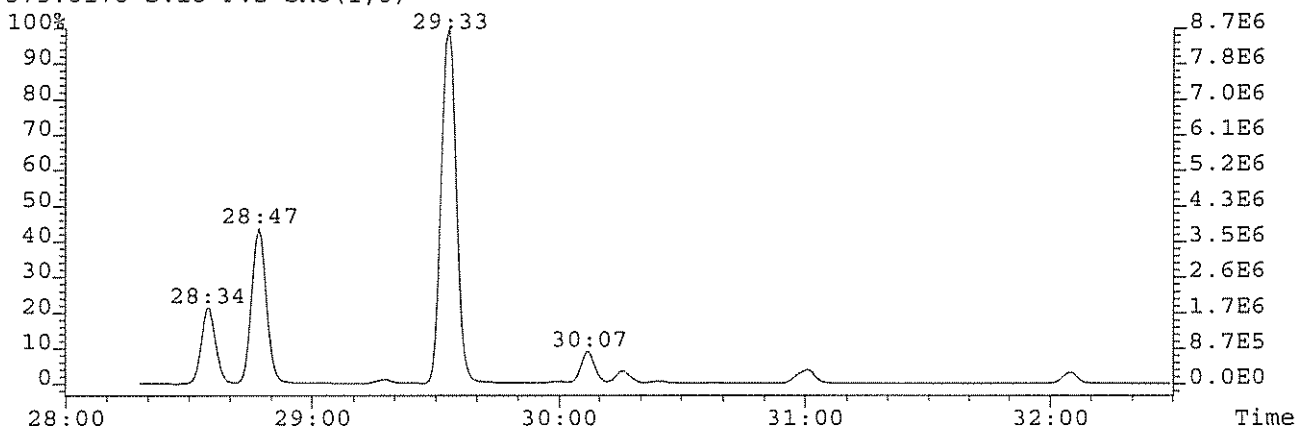
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130710-2 #1-1118 Acq:11-JUL-2013 05:04:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:BPX-DXN(4-6DXN) Text:XE13 0948 Exp:BPX04

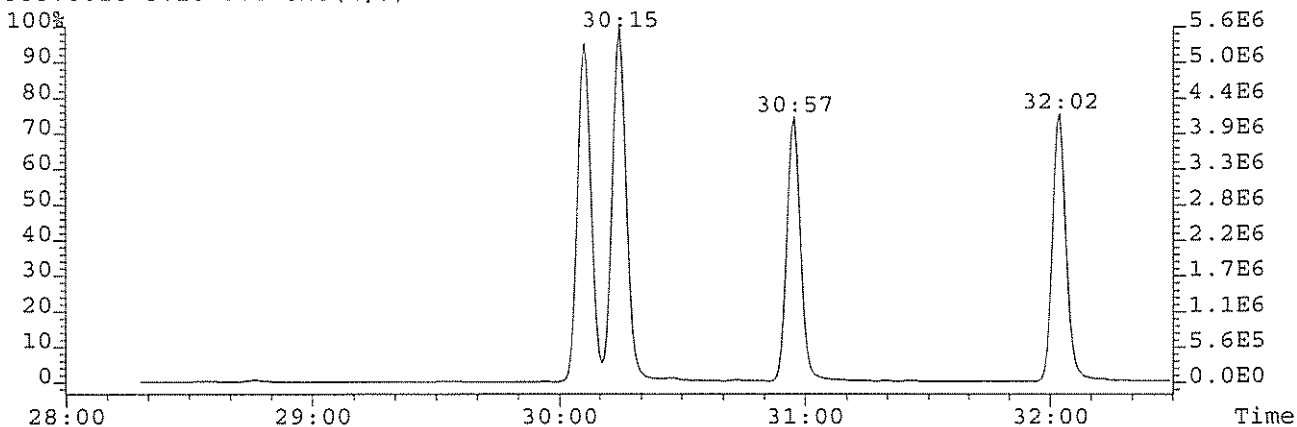
373.8207 S:18 F:2 SMO(1,3)



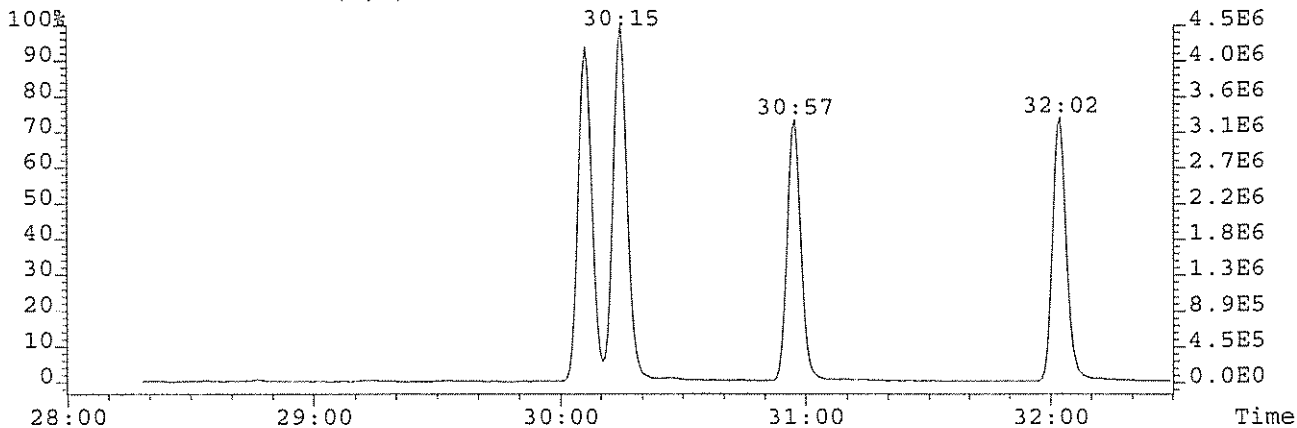
375.8178 S:18 F:2 SMO(1,3)



385.8610 S:18 F:2 SMO(1,3)

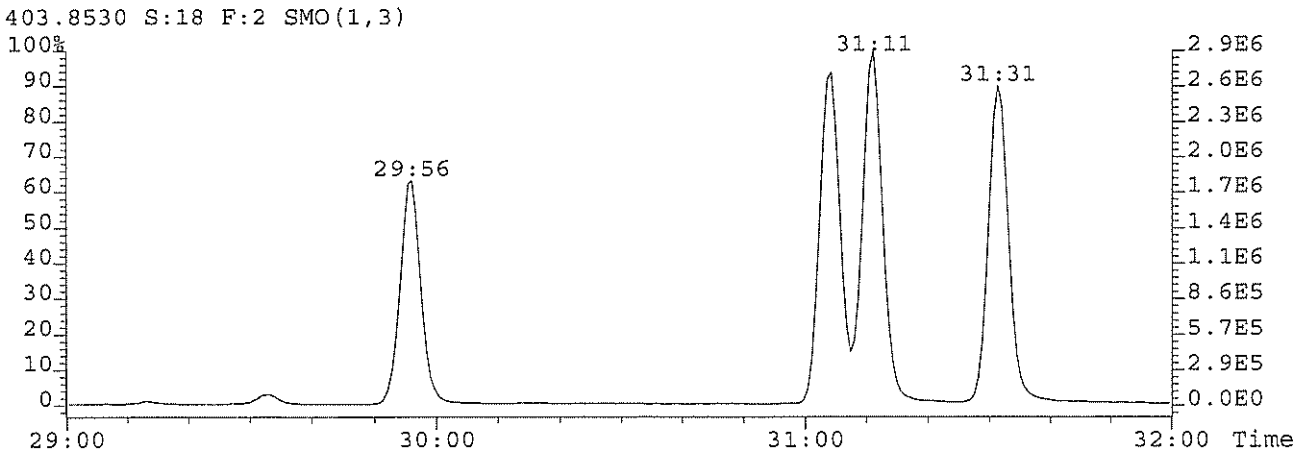
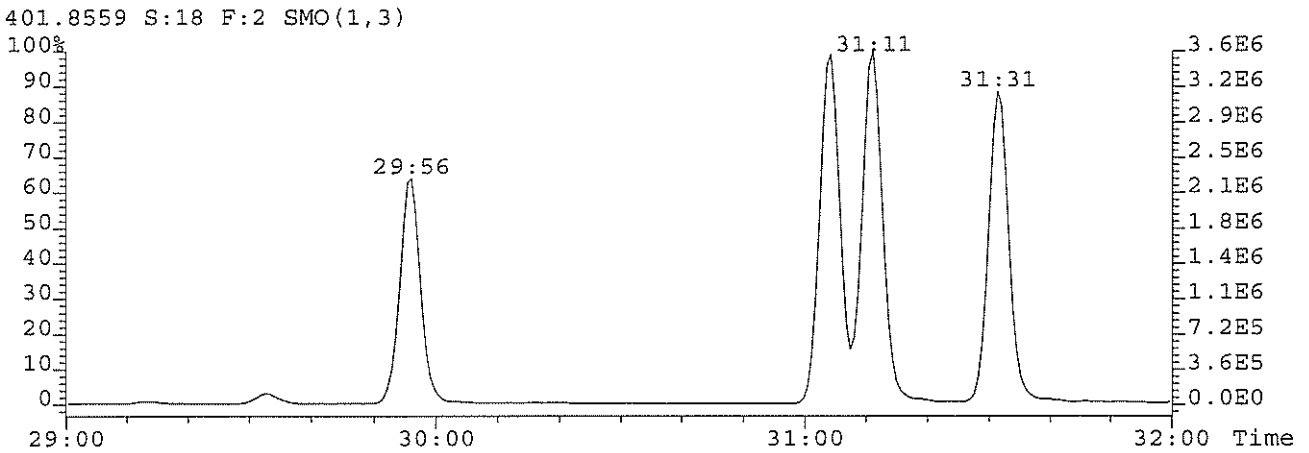
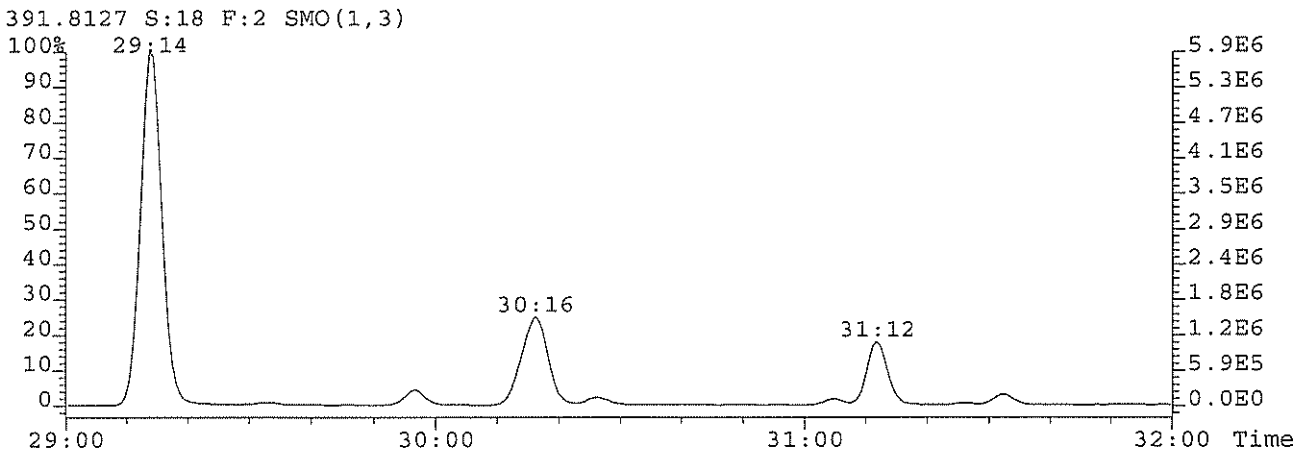
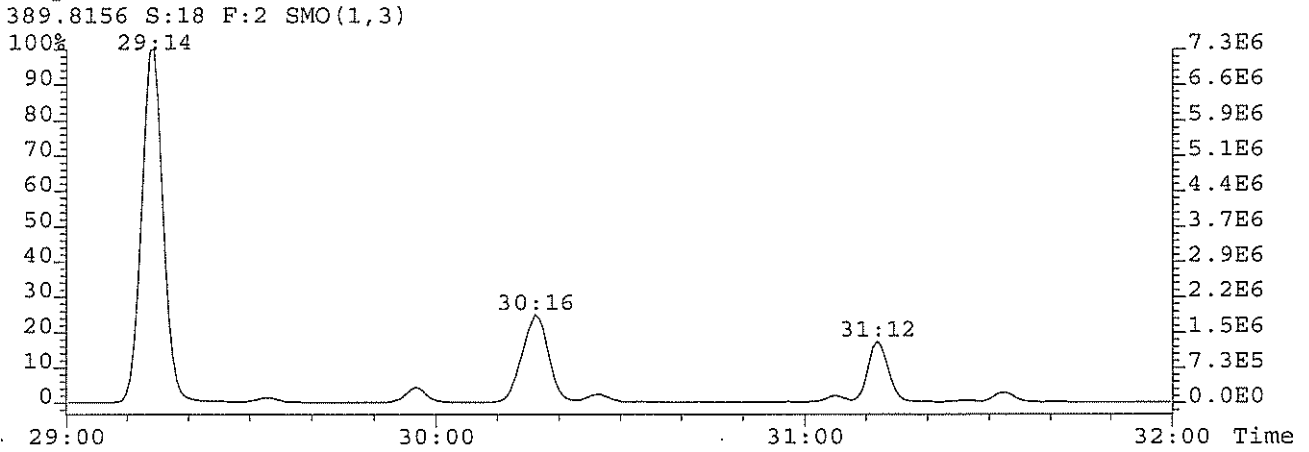


387.8580 S:18 F:2 SMO(1,3)



PCDFsクロマトグラム (5)  
(HxCDFs)

File:130710-2 #1-1118 Acq:11-JUL-2013 05:04:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:BPX-DXN(4-6DXN) Text:XE13 0948 Exp:BPX04

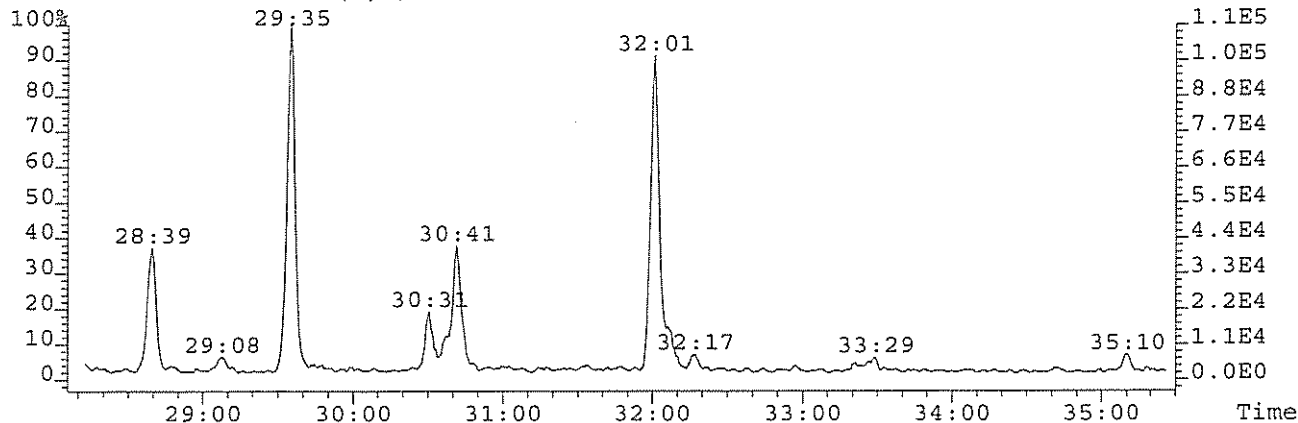


PCDDsクロマトグラム (6)  
(HxCDDs)

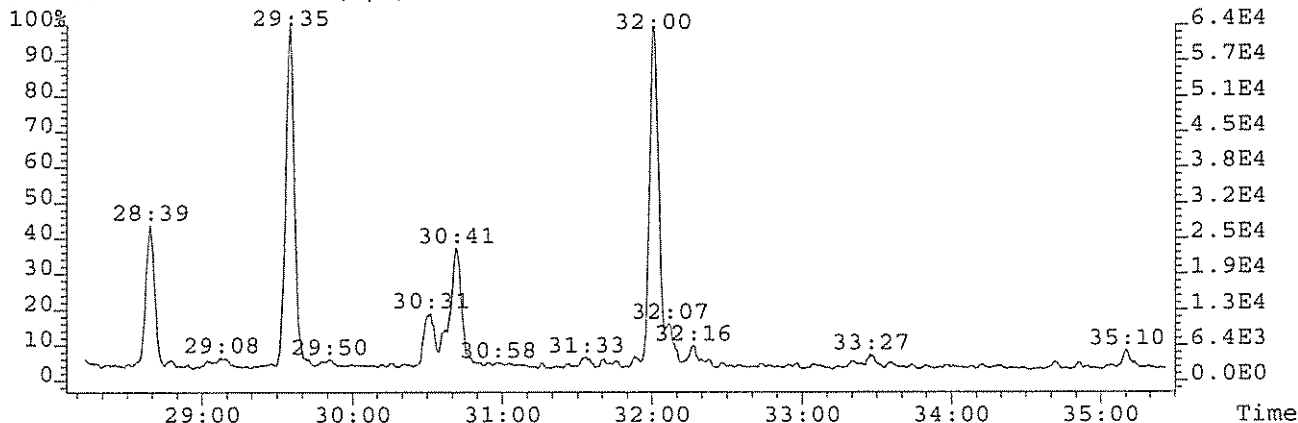


File:130711-2 #1-649 Acq:12-JUL-2013 02:19:07 GC EI+ Voltage SIR Autospec-UltimaE  
 Sample#10 File Text:RH-12ms(5-8,nP) Text:XE13 0948 3 Exp:RH-PD22

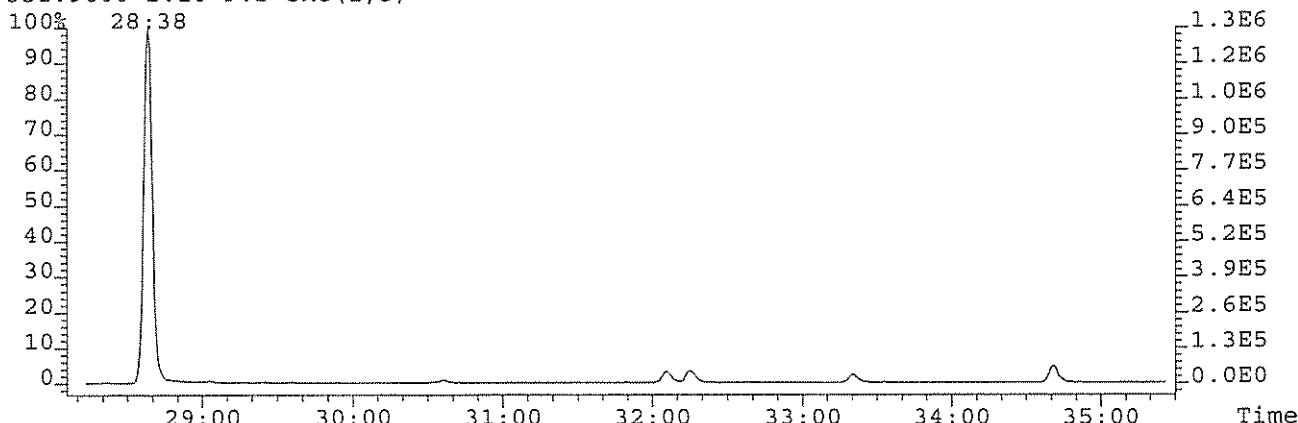
339.8597 S:10 F:2 SMO(1,3)



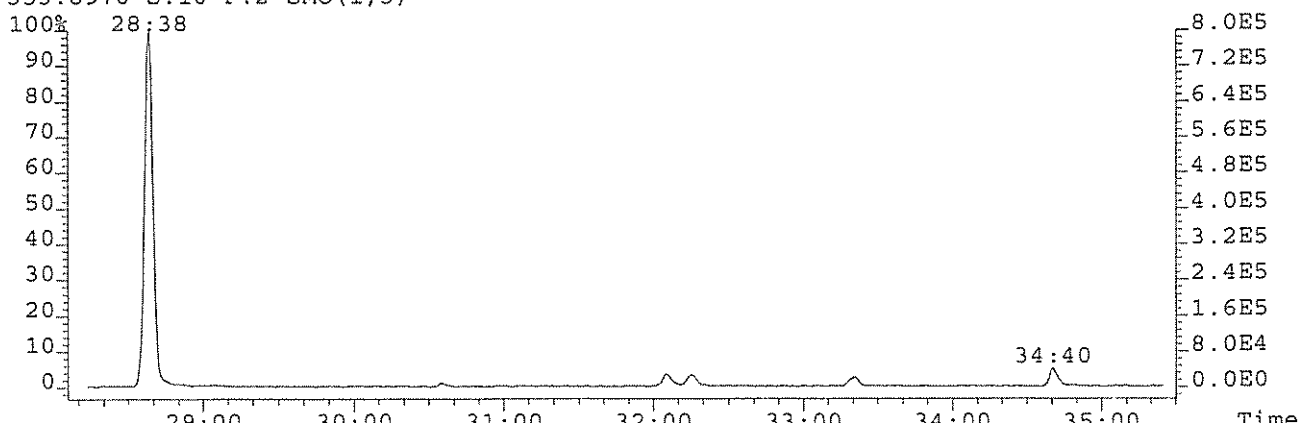
341.8568 S:10 F:2 SMO(1,3)



351.9000 S:10 F:2 SMO(1,3)

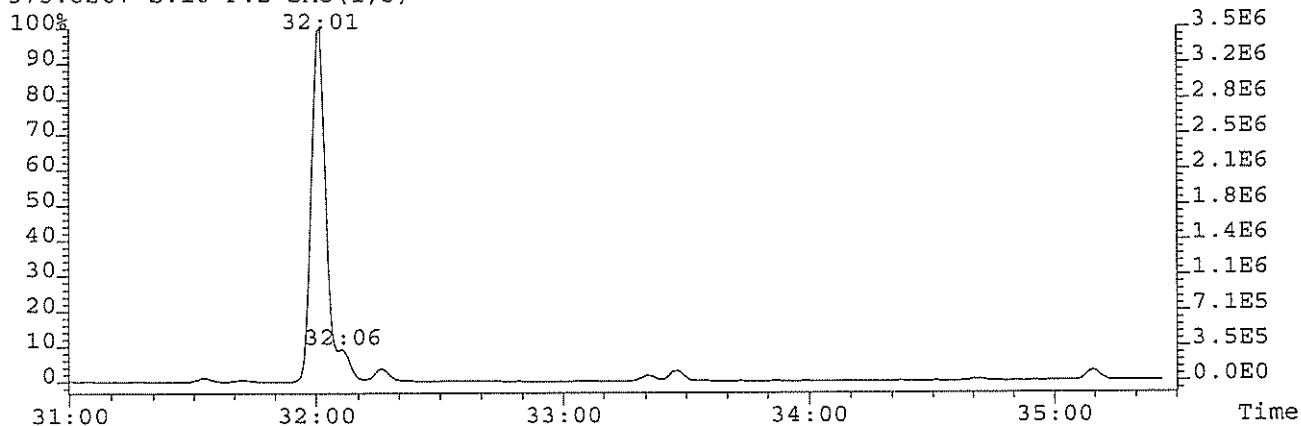


353.8970 S:10 F:2 SMO(1,3)

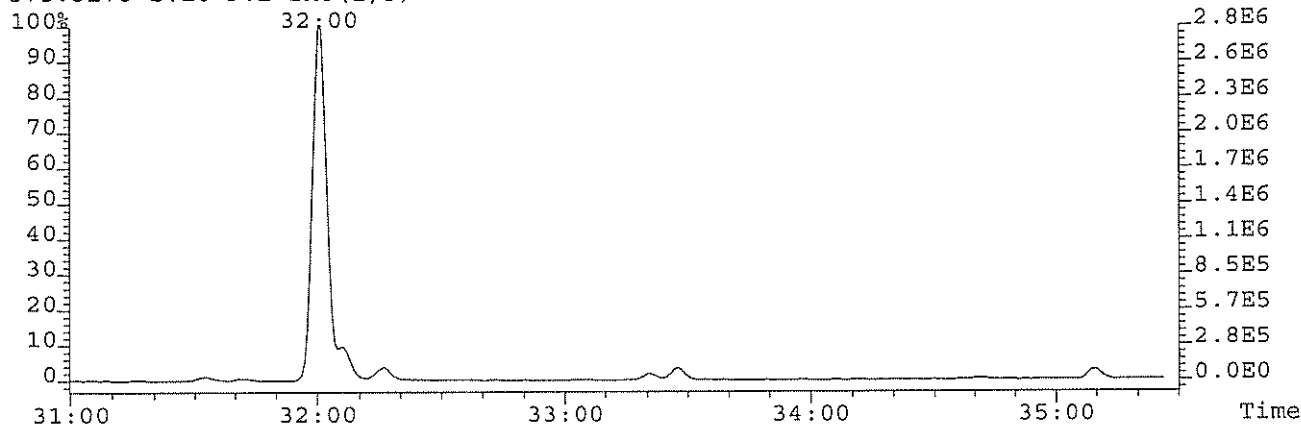


PeCDFsクロマトグラム (7)  
 (23478-PeCDF)

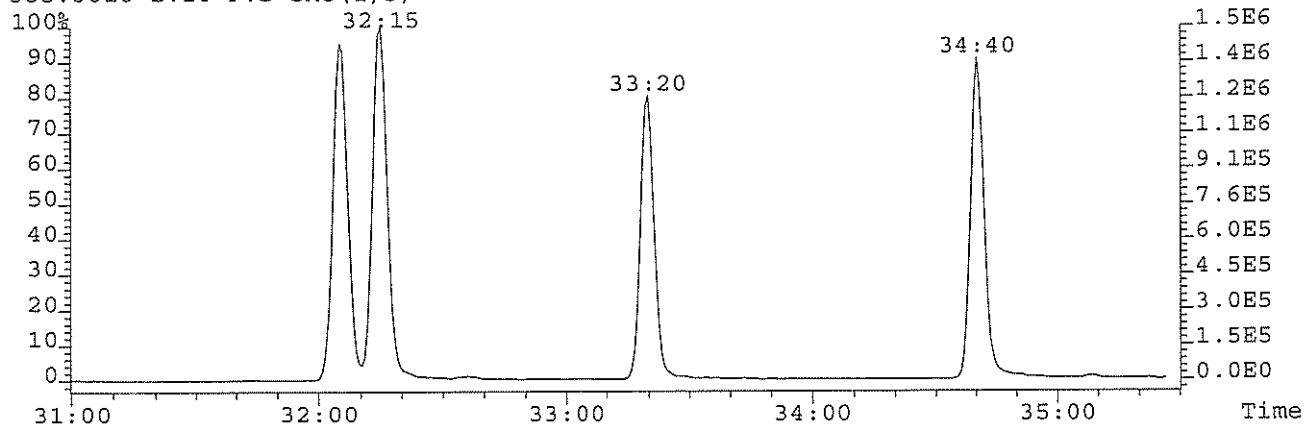
File:130711-2 #1-649 Acq:12-JUL-2013 02:19:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:RH-12ms(5-8,nP) Text:XE13 0948 3 Exp:RH-PD22  
373.8207 S:10 F:2 SMO(1,3)



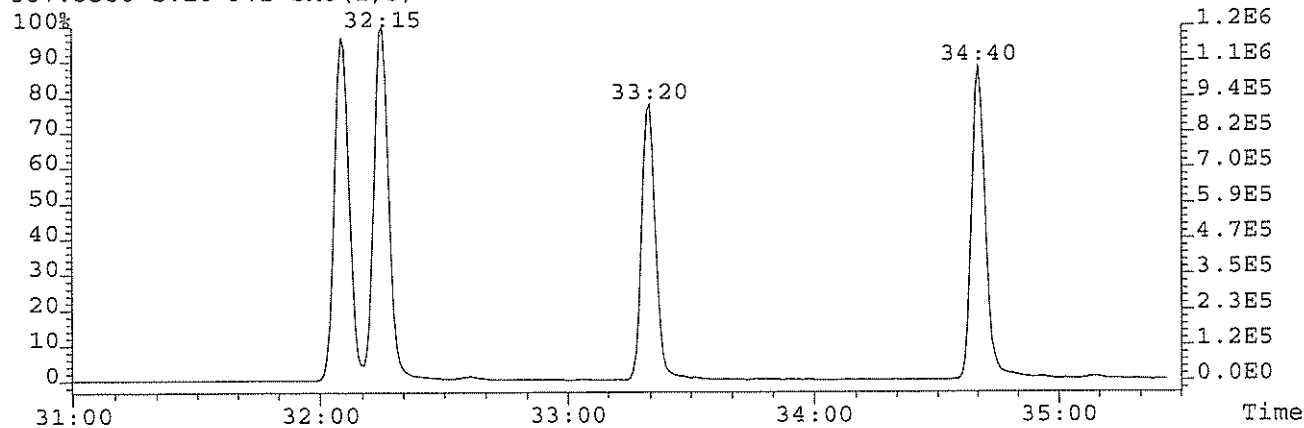
375.8178 S:10 F:2 SMO(1,3)



385.8610 S:10 F:2 SMO(1,3)

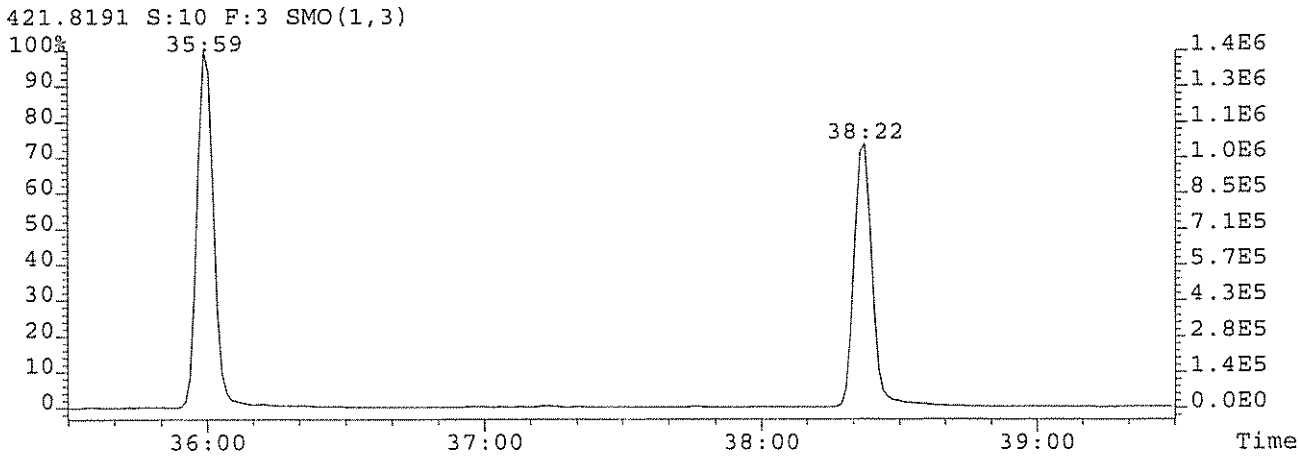
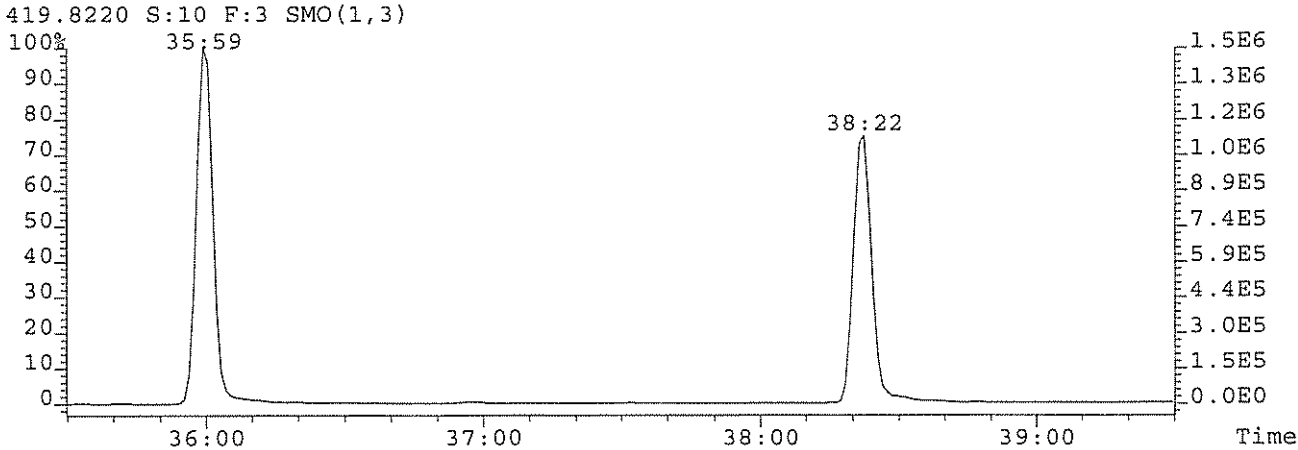
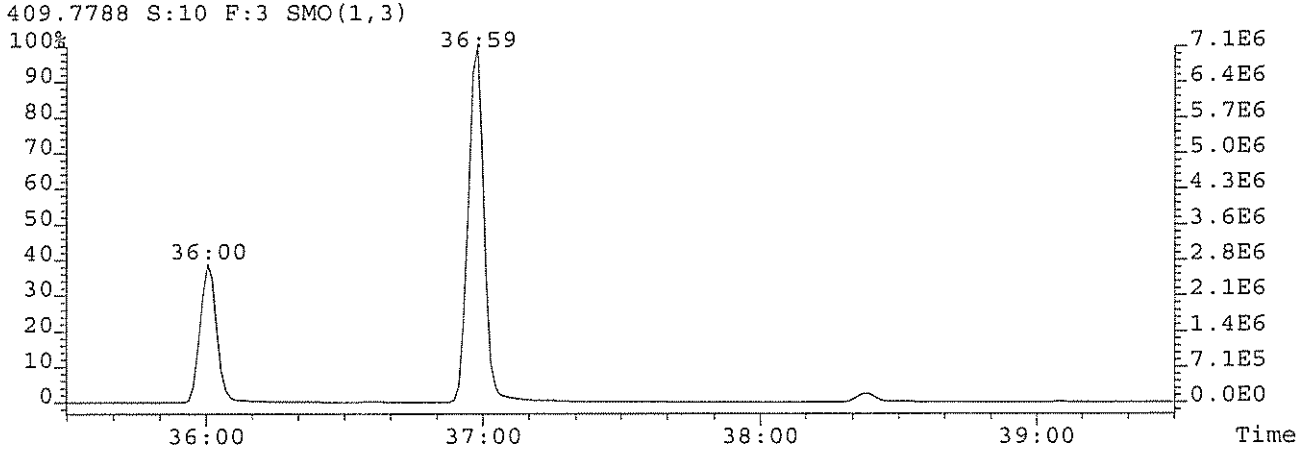
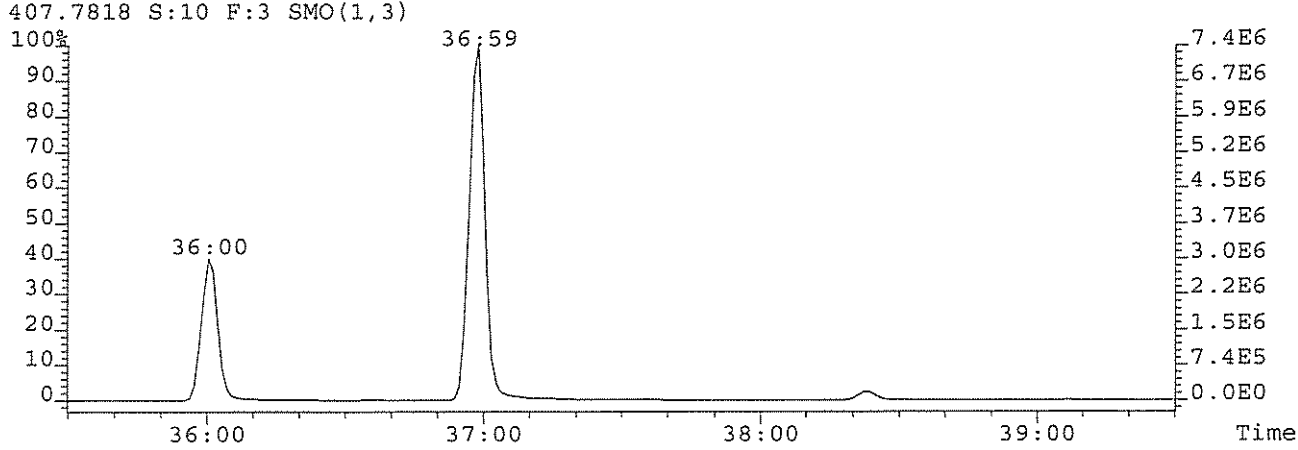


387.8580 S:10 F:2 SMO(1,3)



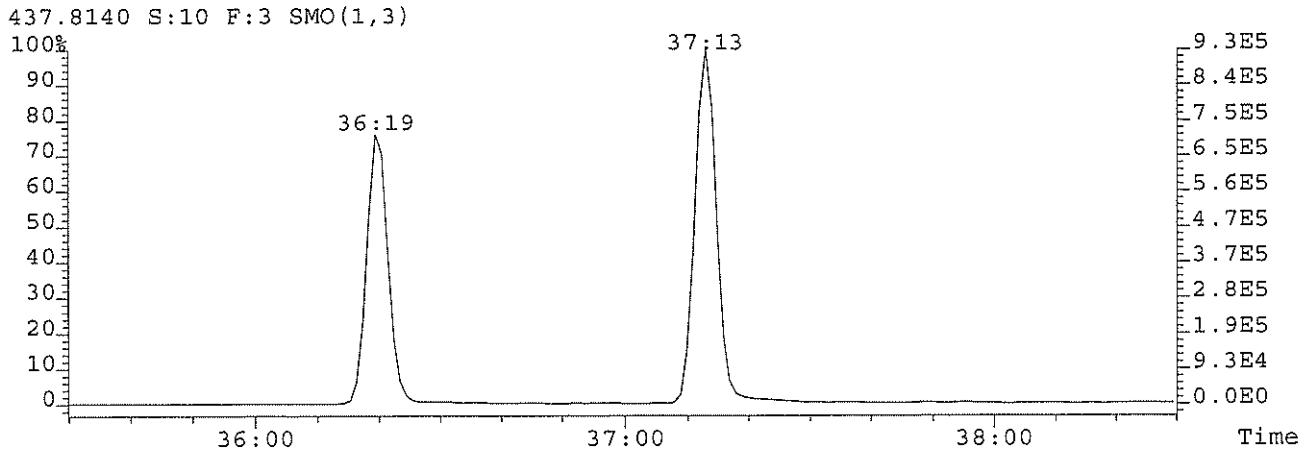
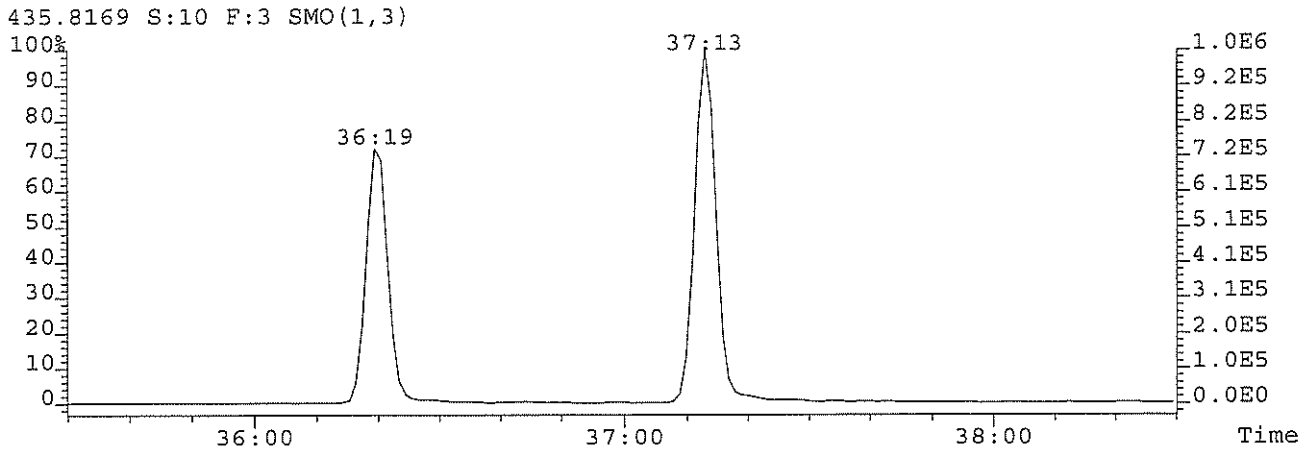
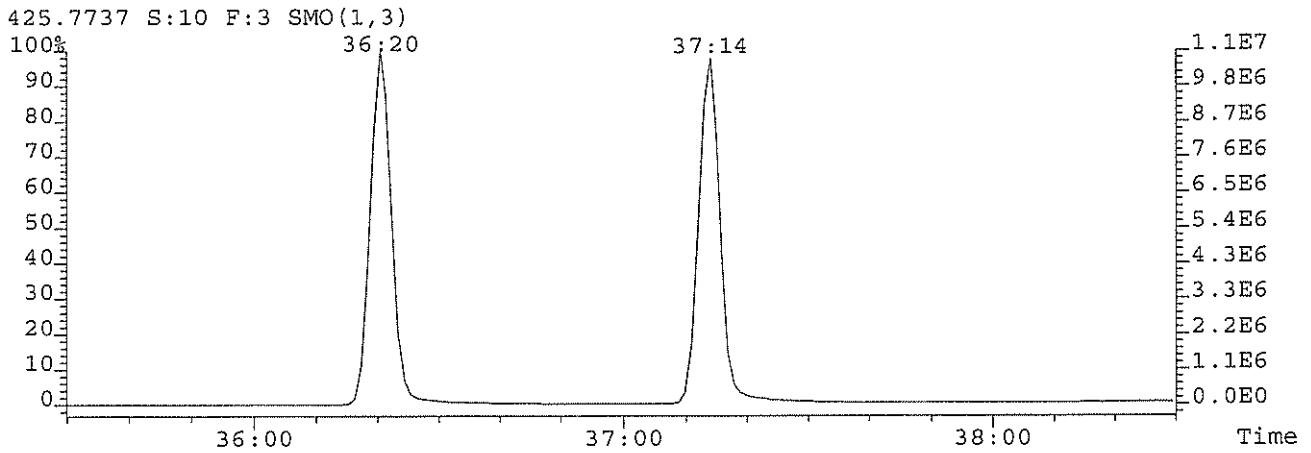
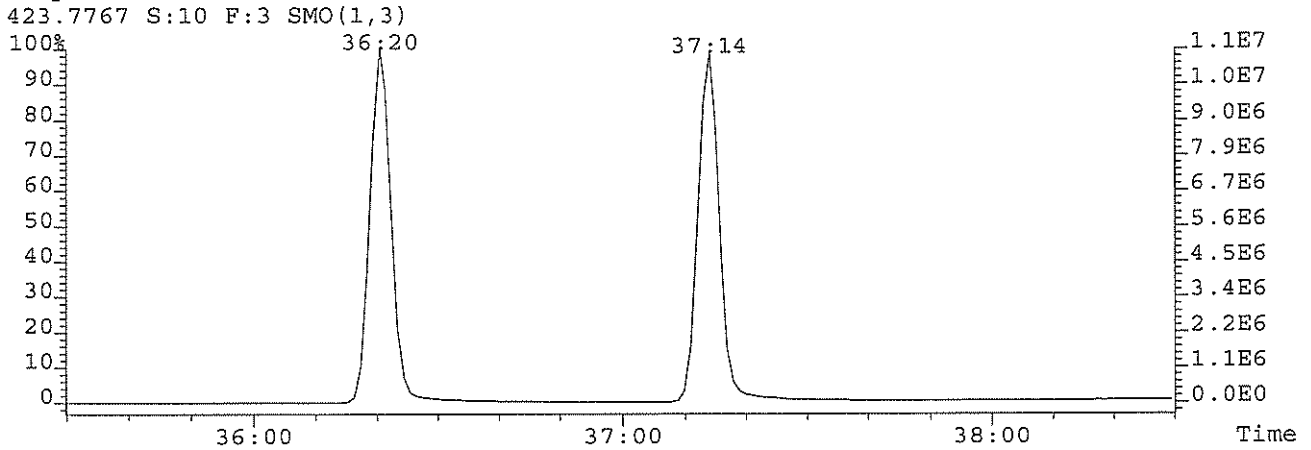
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130711-2 #1-562 Acq:12-JUL-2013 02:19:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:RH-12ms(5-8,nP) Text:XE13 0948 3 Exp:RH-PD22



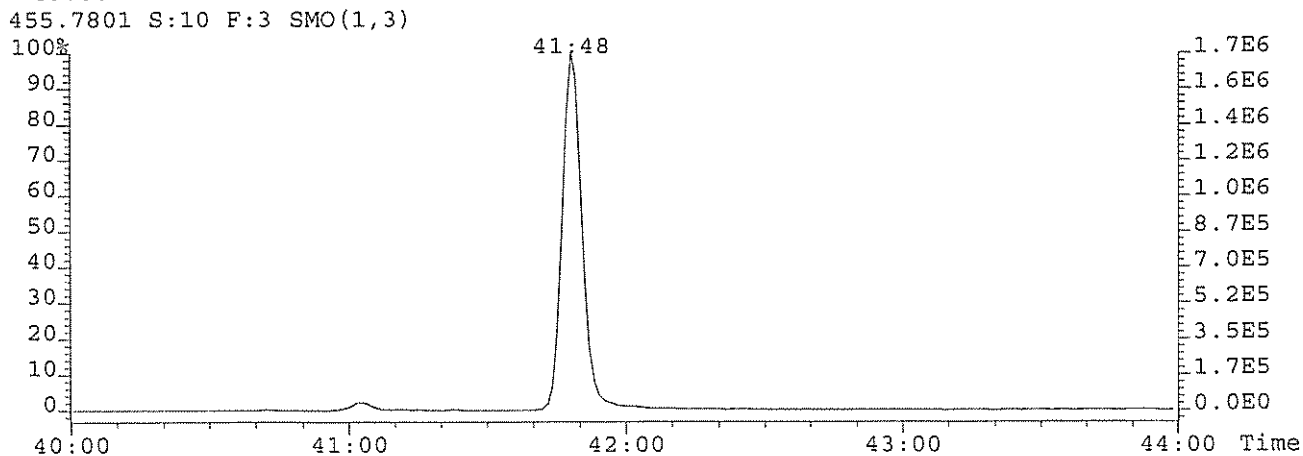
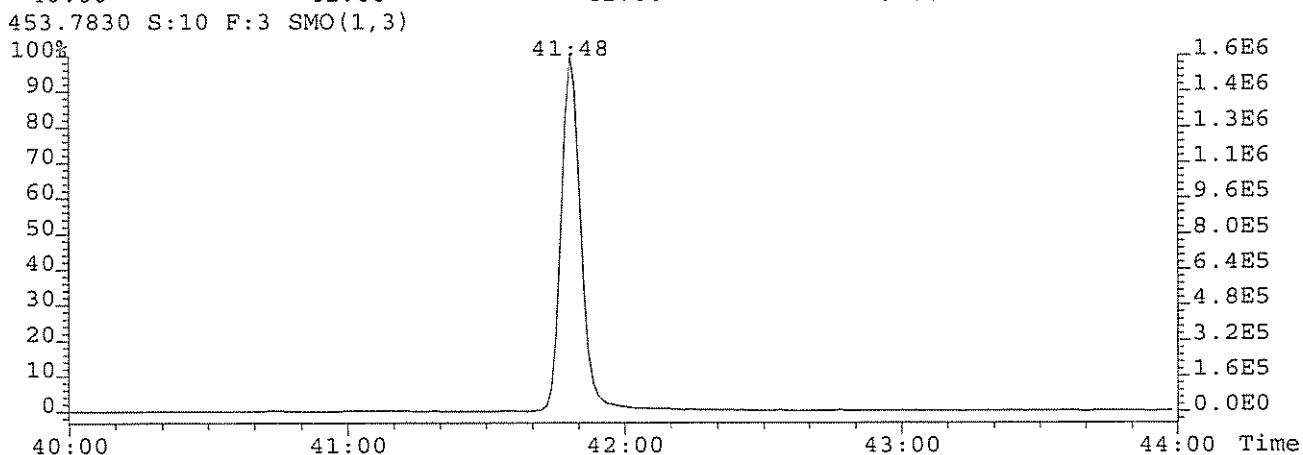
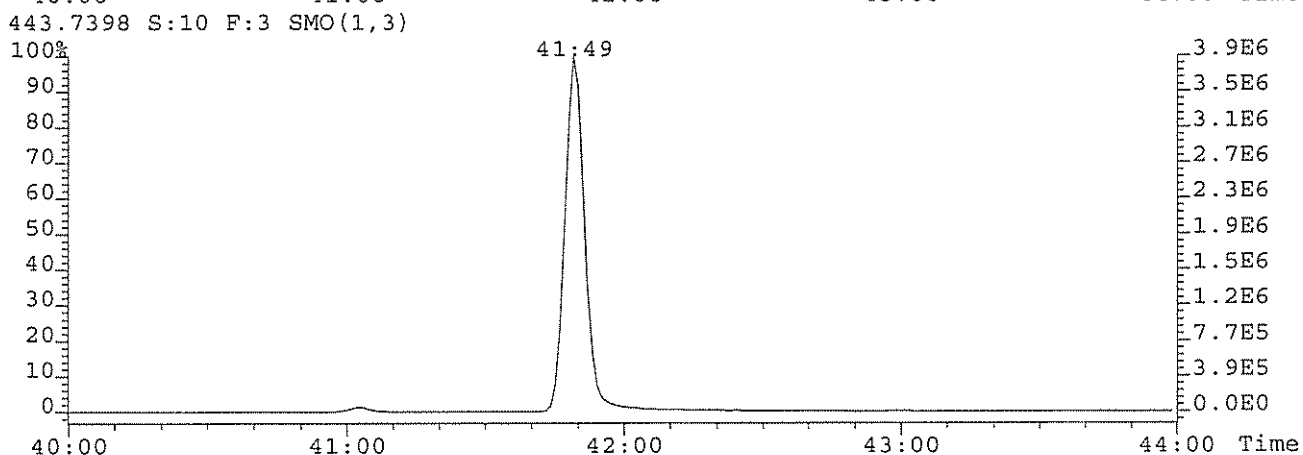
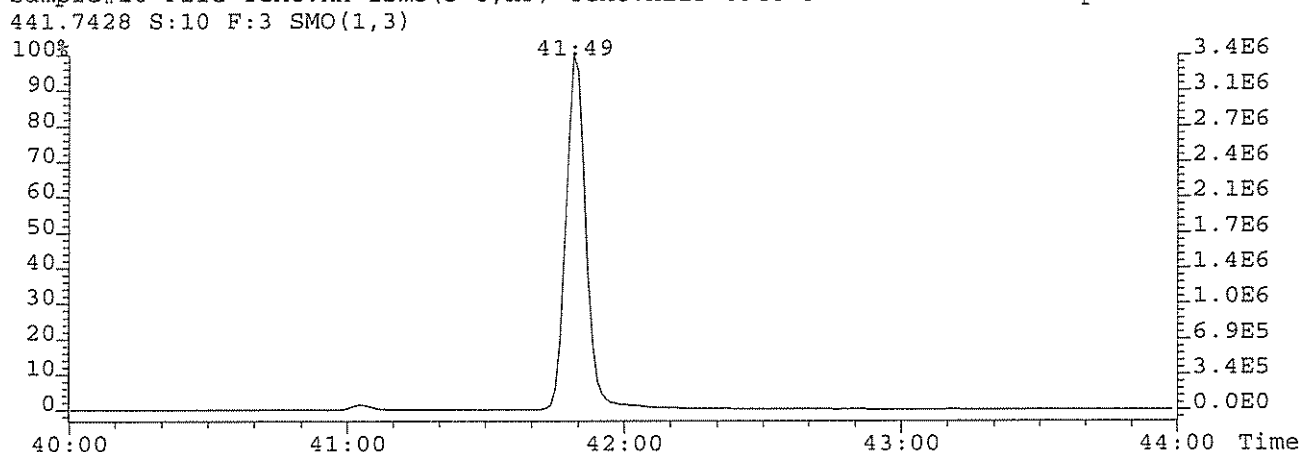
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130711-2 #1-562 Acq:12-JUL-2013 02:19:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:RH-12ms(5-8,nP) Text:XE13 0948 3 Exp:RH-PD22



PCDDsクロマトグラム (10)  
(HpCDDs)

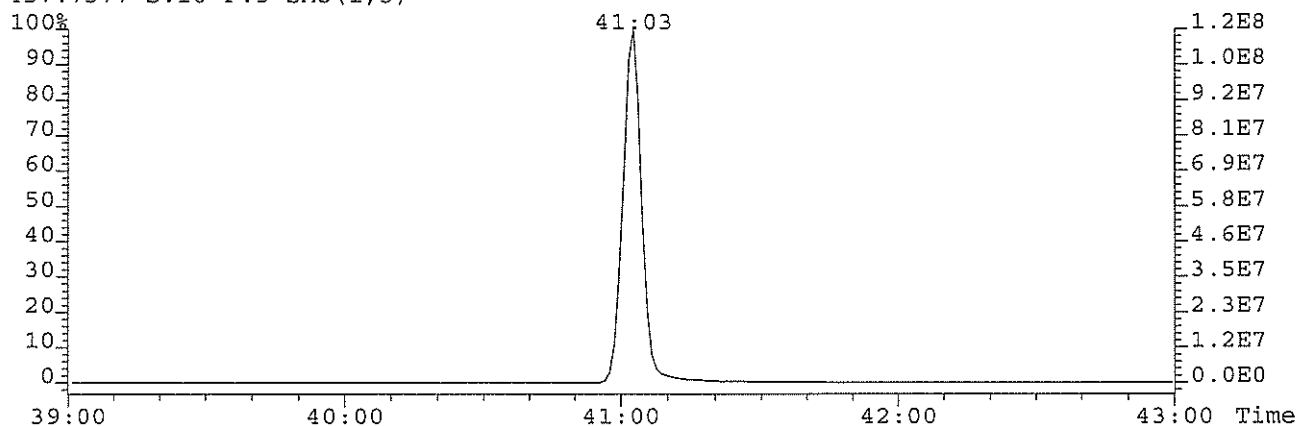
File:130711-2 #1-562 Acq:12-JUL-2013 02:19:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:RH-12ms(5-8,nP) Text:XE13 0948 3 Exp:RH-PD22



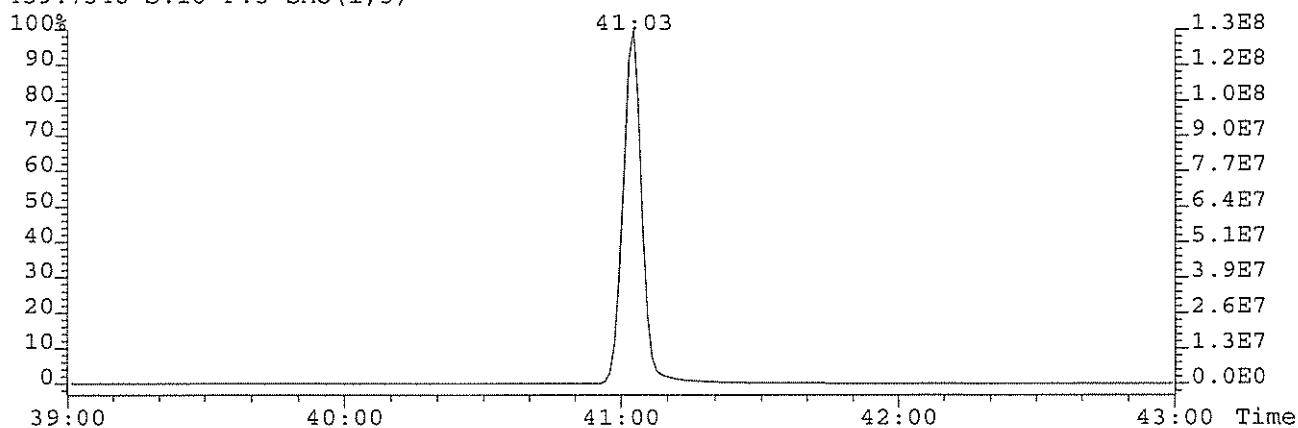
PCDFsクロマトグラム (11)  
(OCDF)

File:130711-2 #1-562 Acq:12-JUL-2013 02:19:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:RH-12ms(5-8,nP) Text:XE13 0948 3 Exp:RH-PD22

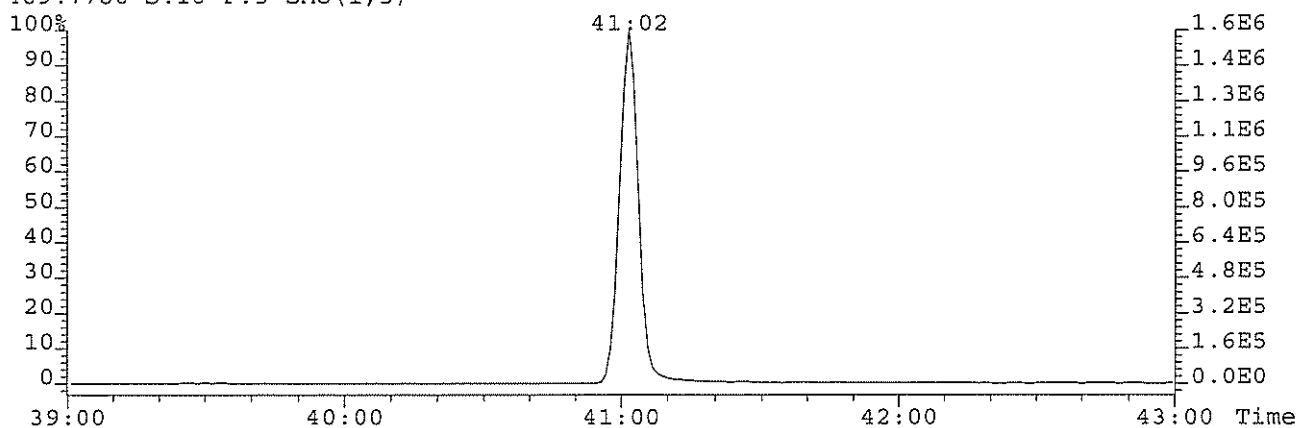
457.7377 S:10 F:3 SMO(1,3)



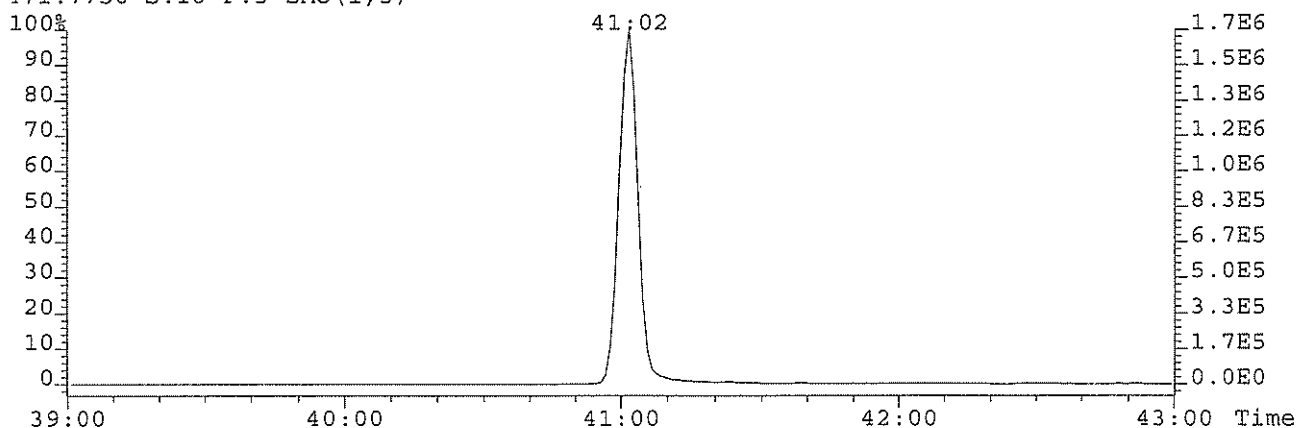
459.7348 S:10 F:3 SMO(1,3)



469.7780 S:10 F:3 SMO(1,3)

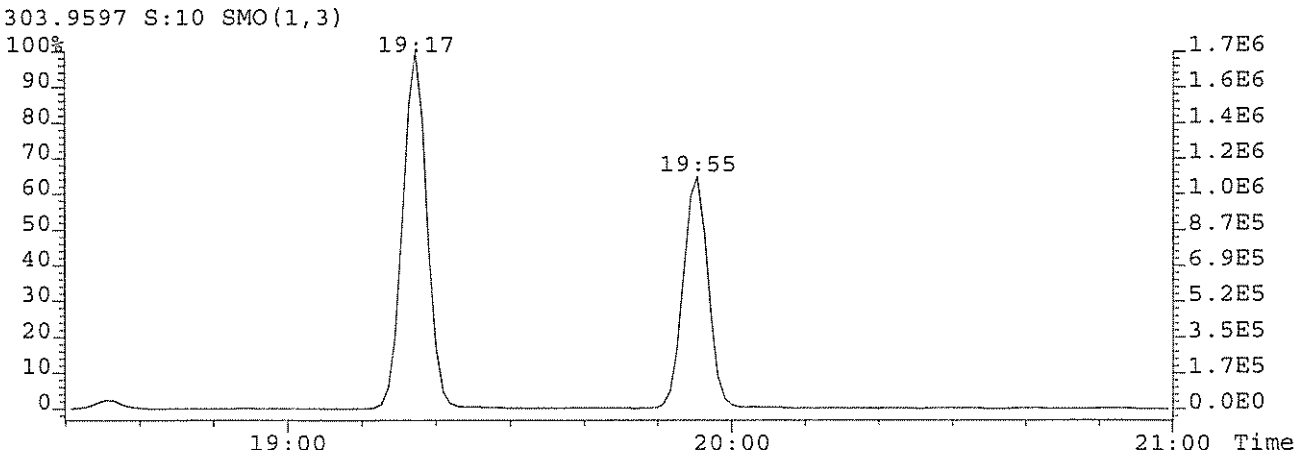
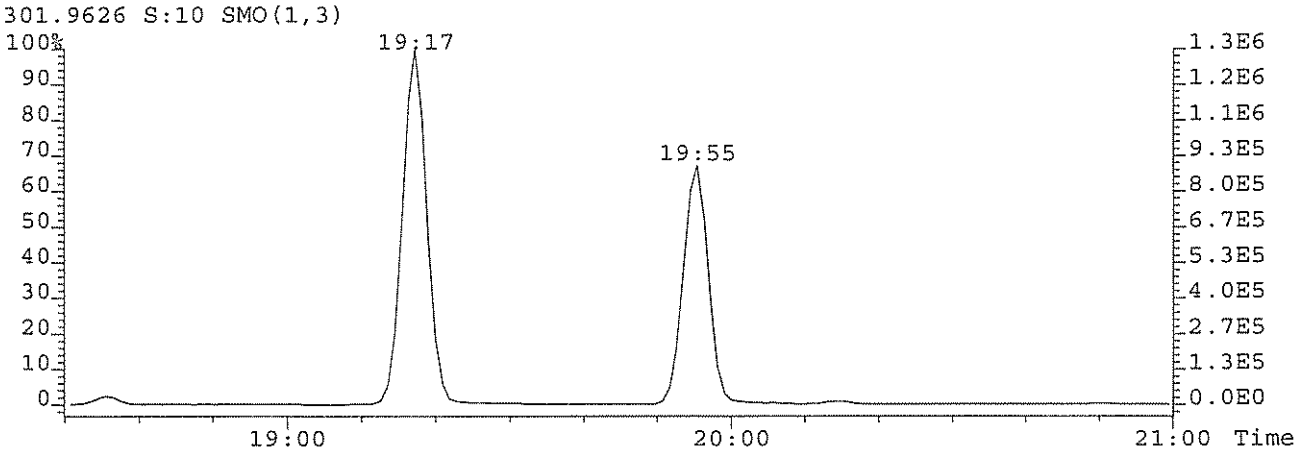
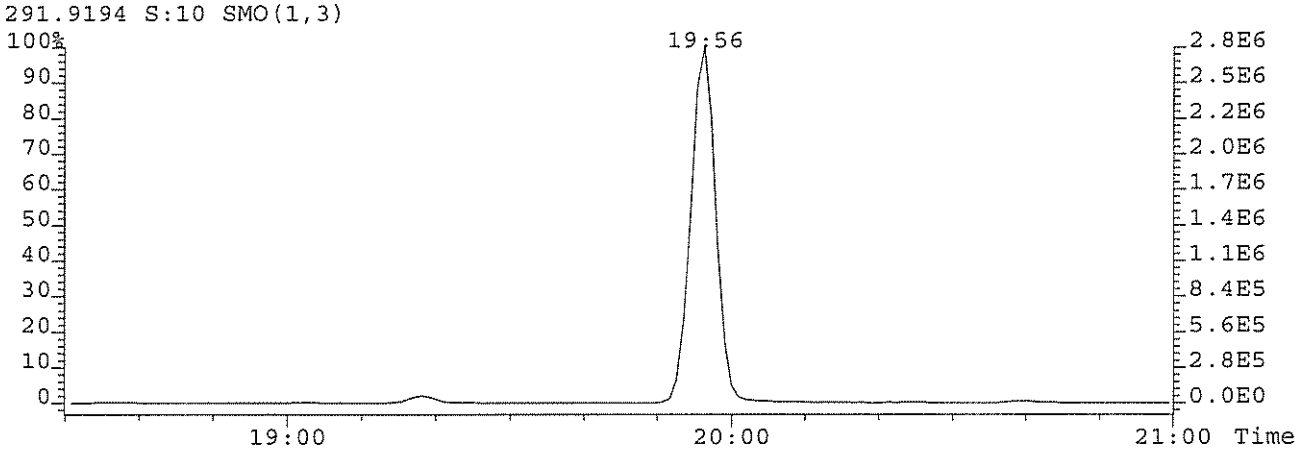
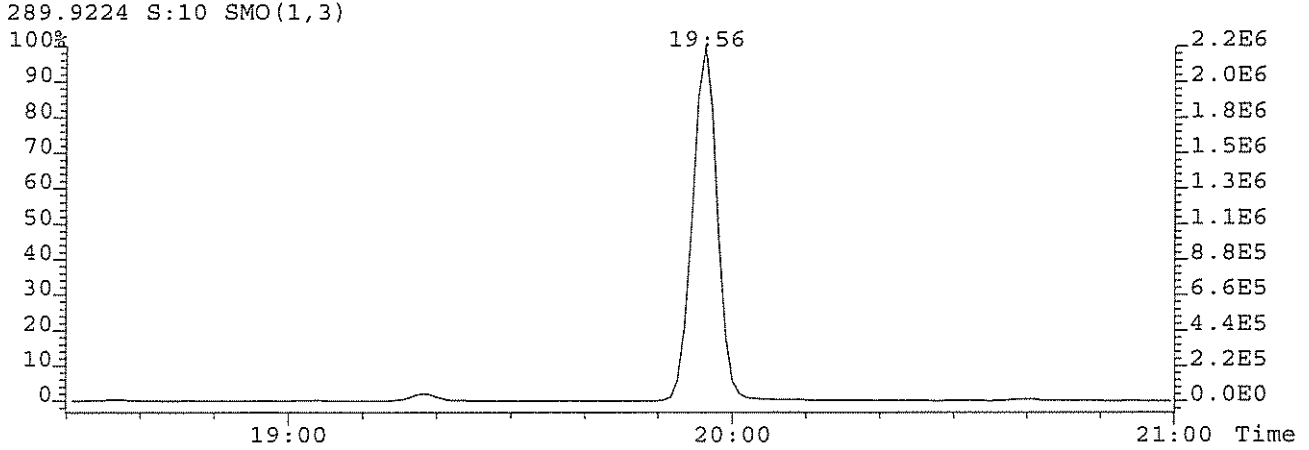


471.7750 S:10 F:3 SMO(1,3)



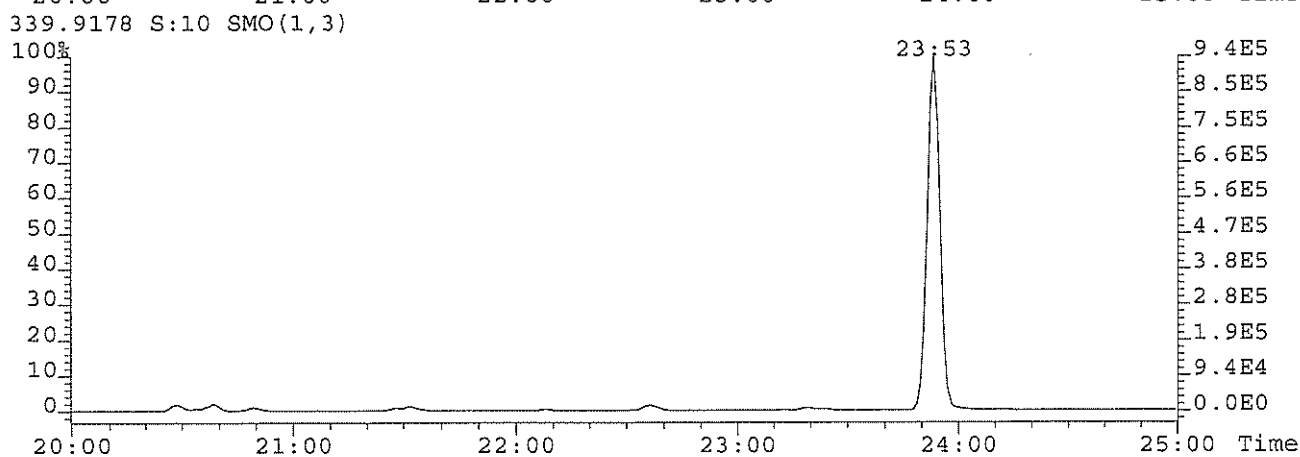
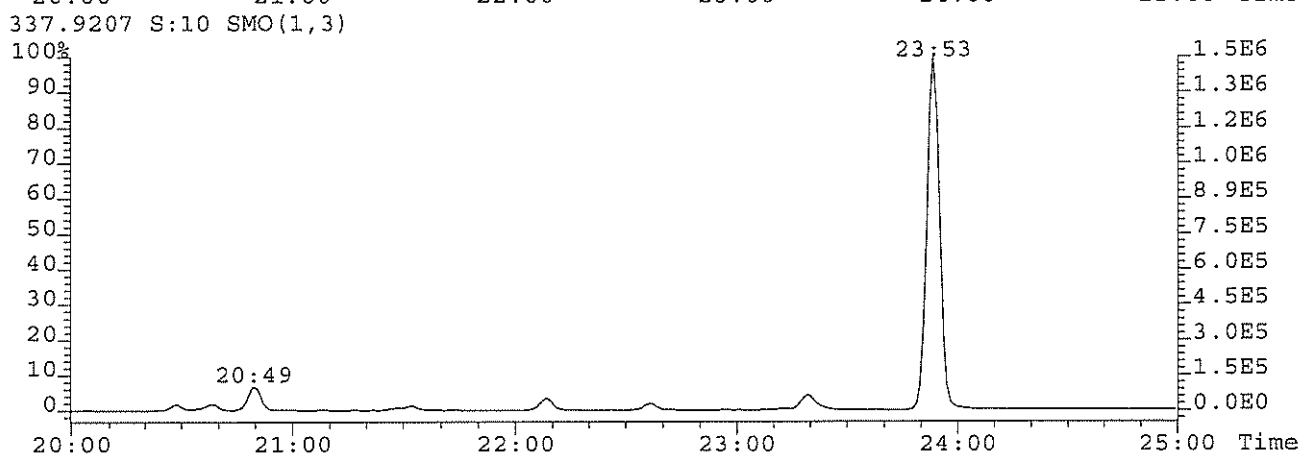
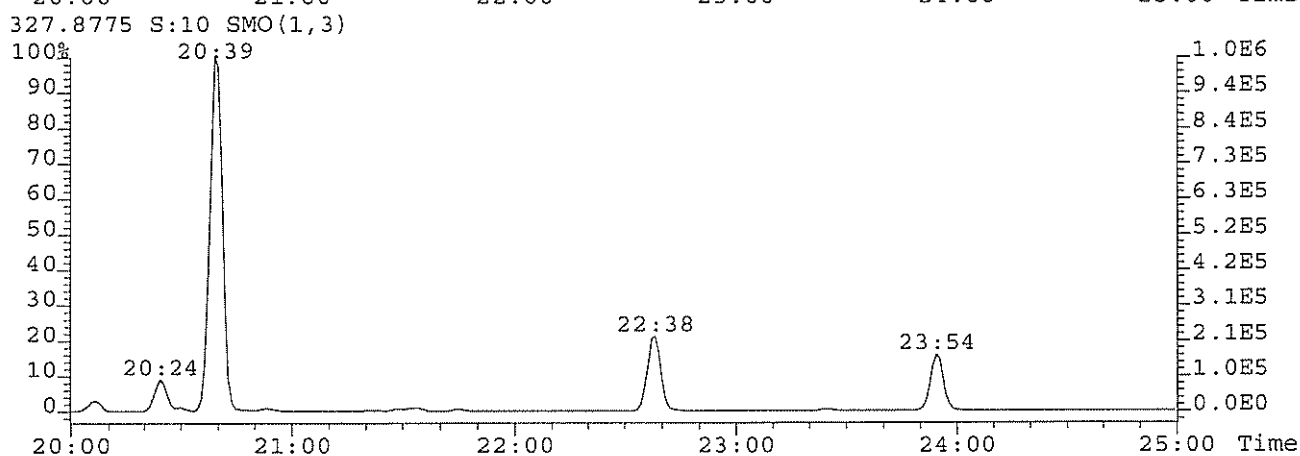
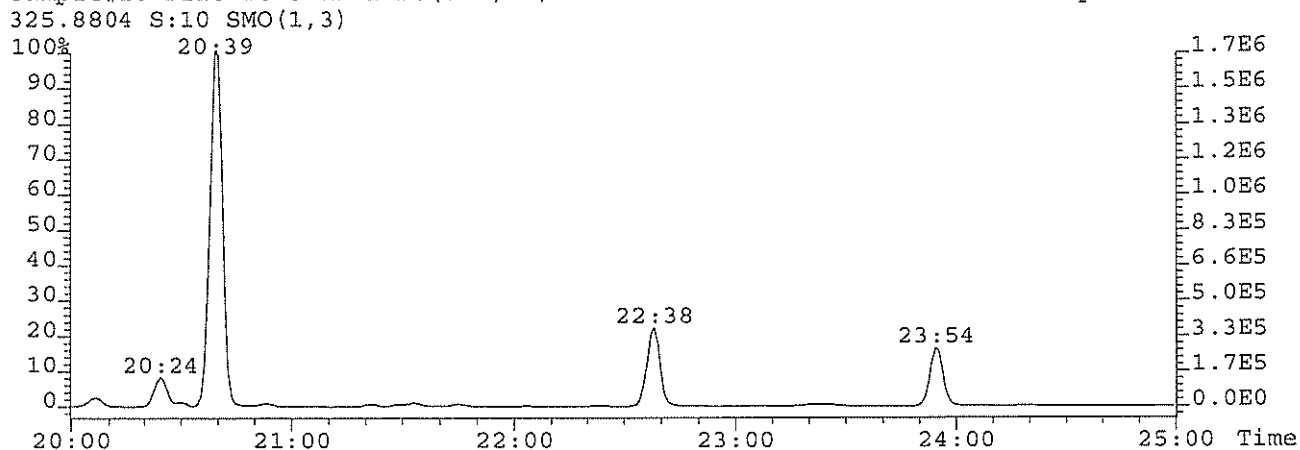
PCDDsクロマトグラム (12)  
(OCDD)

File:130711-2 #1-1430 Acq:12-JUL-2013 02:19:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:RH-12ms(5-8,nP) Text:XE13 0948 3 Exp:RH-PD22



DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

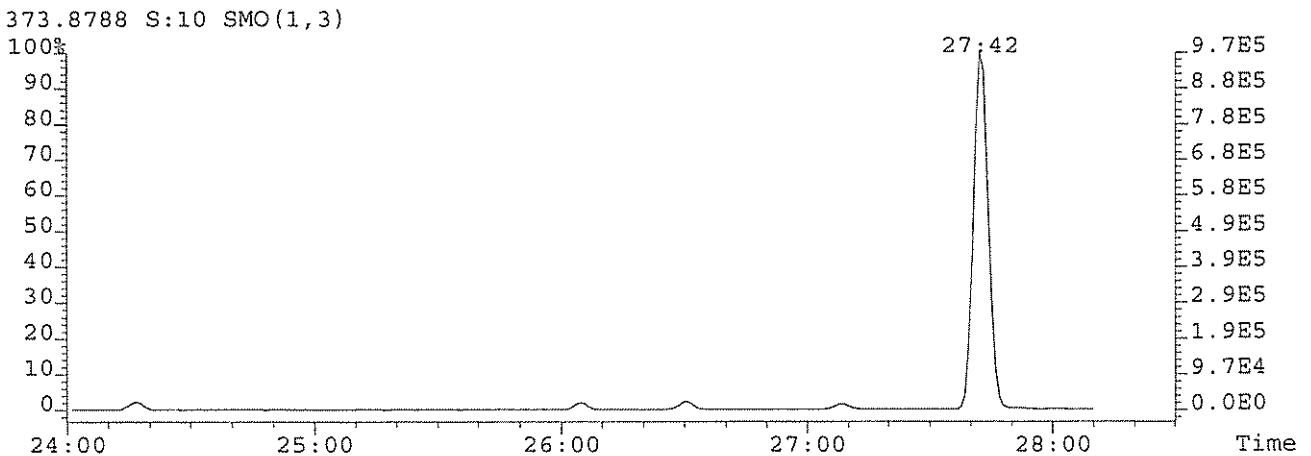
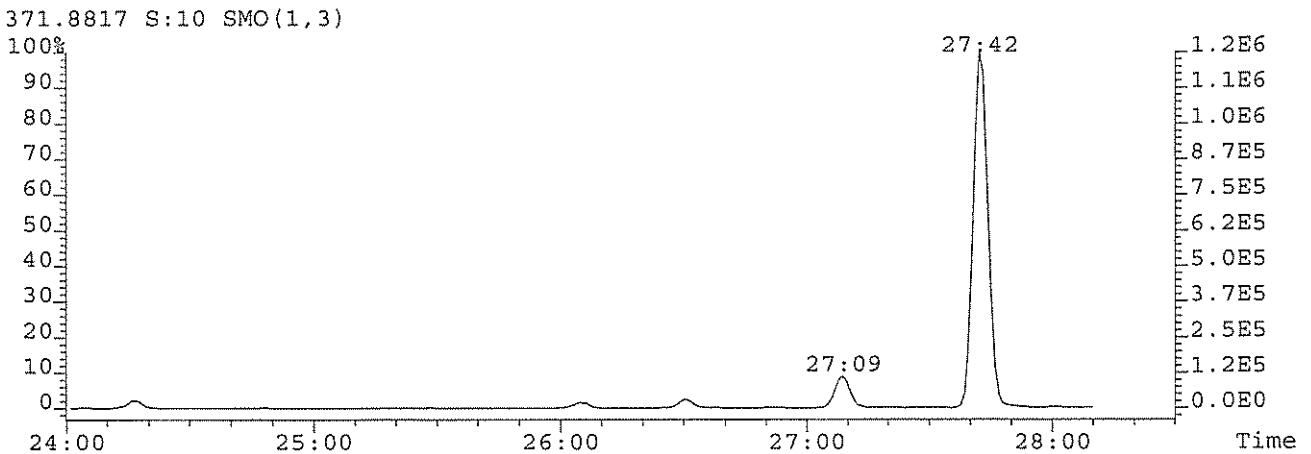
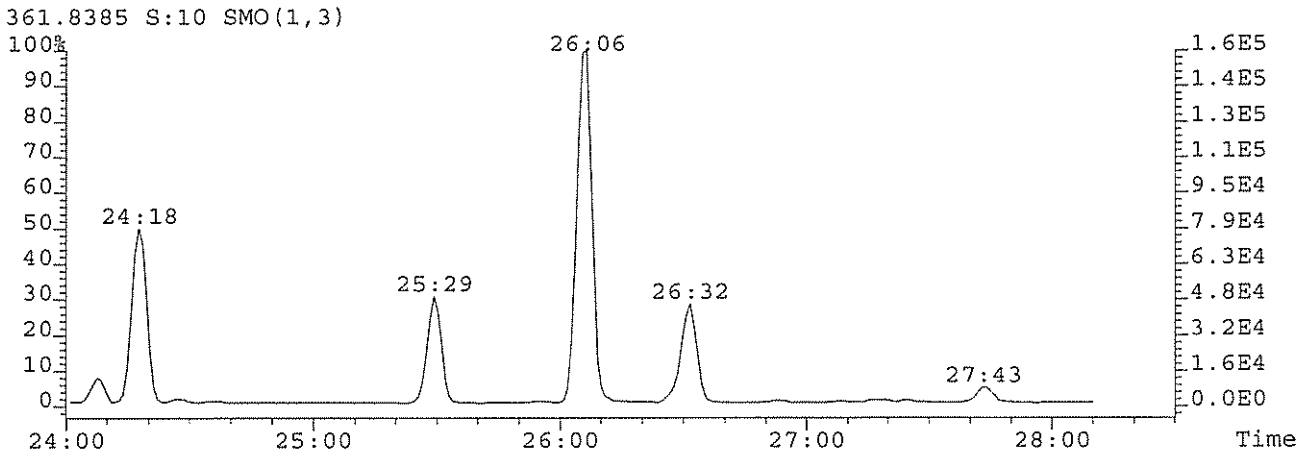
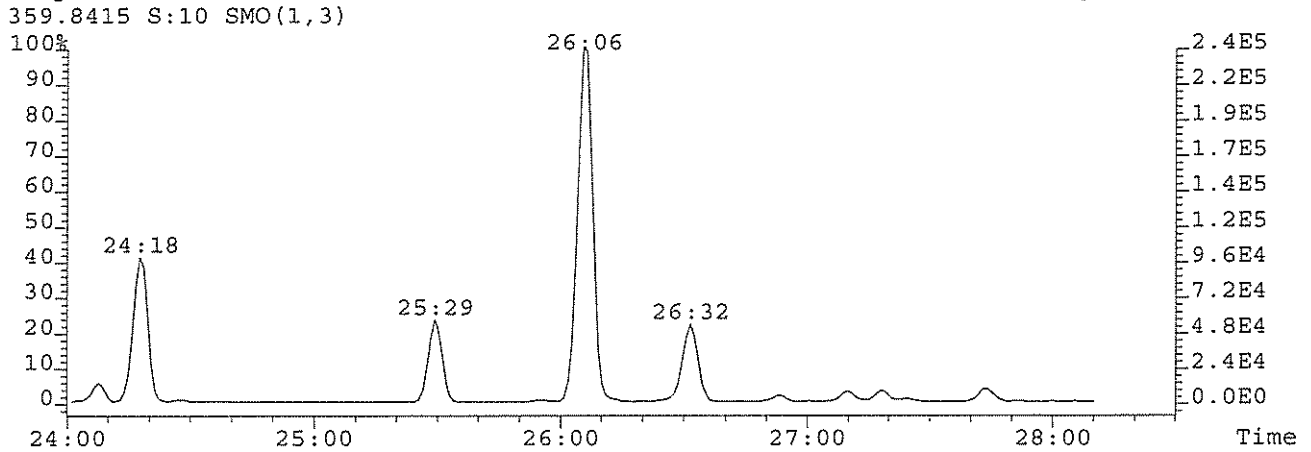
File:130711-2 #1-1430 Acq:12-JUL-2013 02:19:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:RH-12ms(5-8,nP) Text:XE13 0948 3 Exp:RH-PD22



DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)



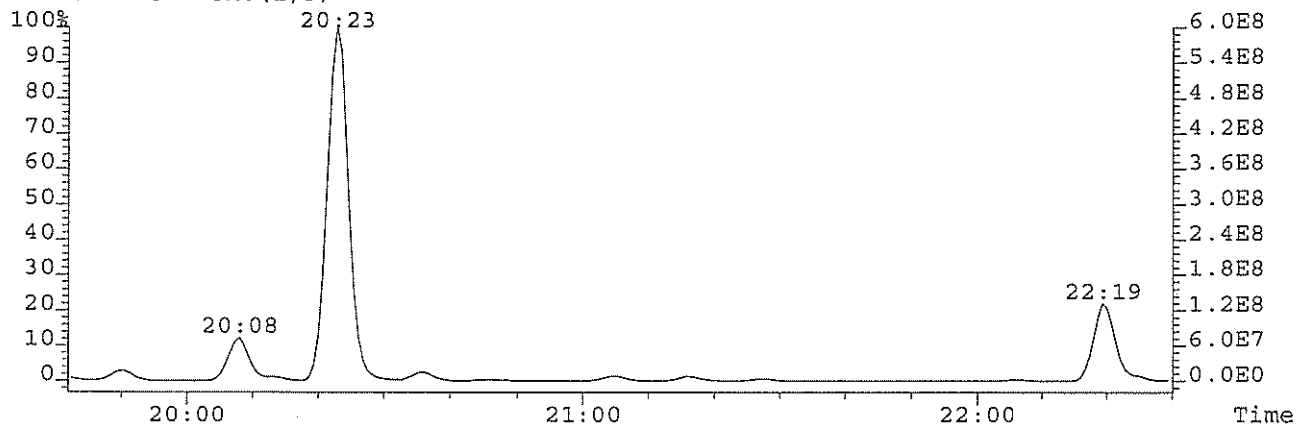
File:130711-2 #1-1430 Acq:12-JUL-2013 02:19:07 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:RH-12ms(5-8,nP) Text:XE13 0948 3 Exp:RH-PD22



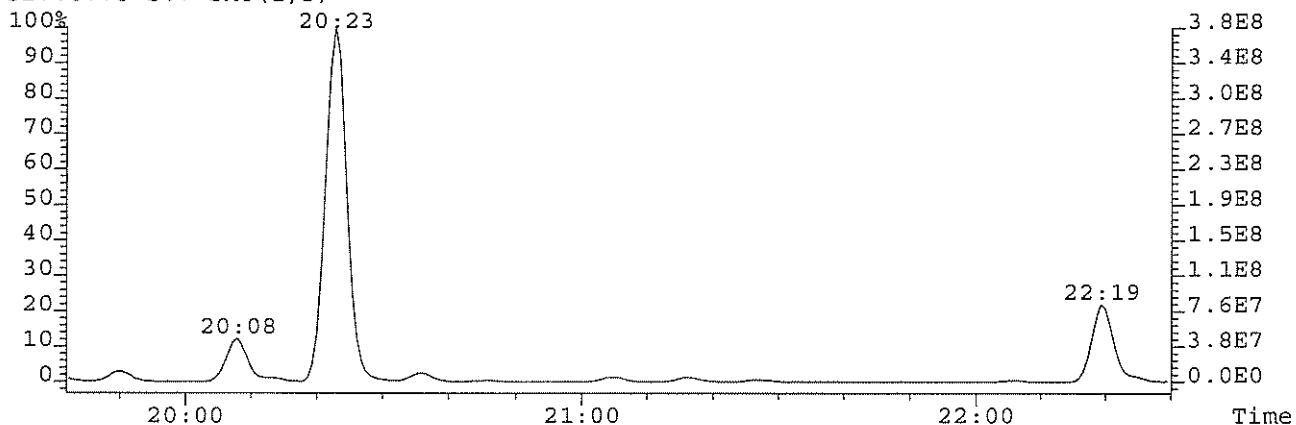
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130711-2 #1-2897 Acq:11-JUL-2013 22:03:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#7 File Text:RH-12ms(mP) Text:XE13 0948 2 Exp:RH-MP11

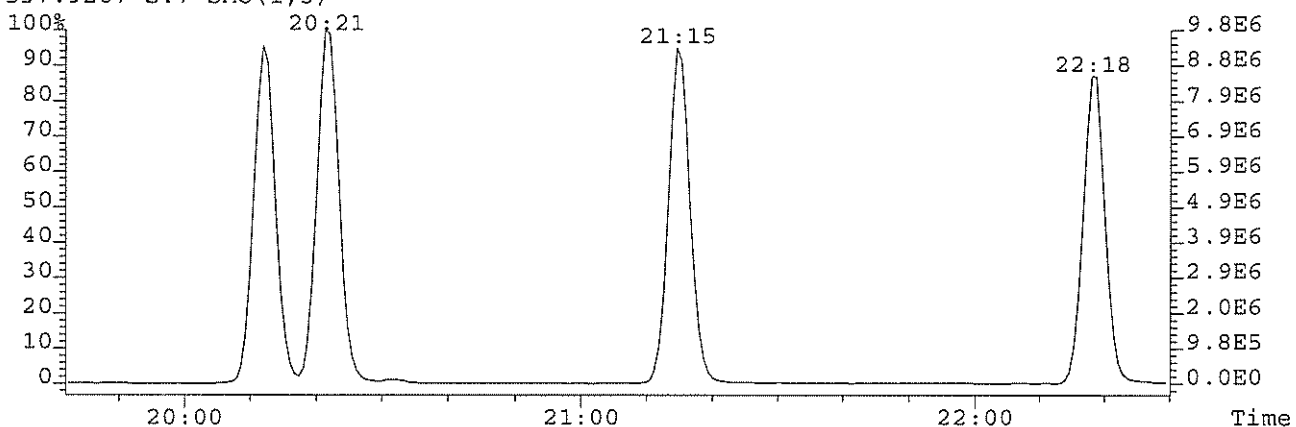
325.8804 S:7 SMO(1,3)



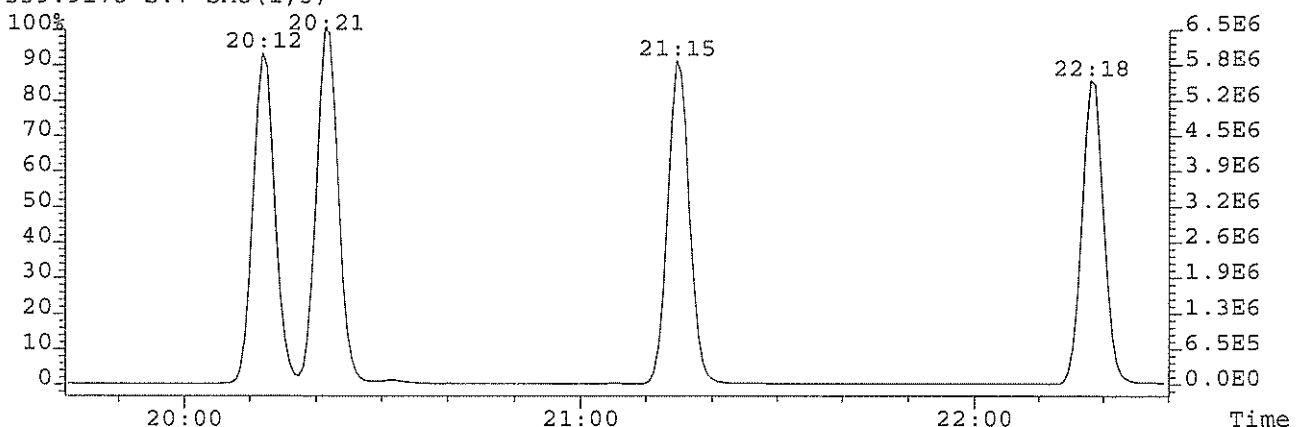
327.8775 S:7 SMO(1,3)



337.9207 S:7 SMO(1,3)



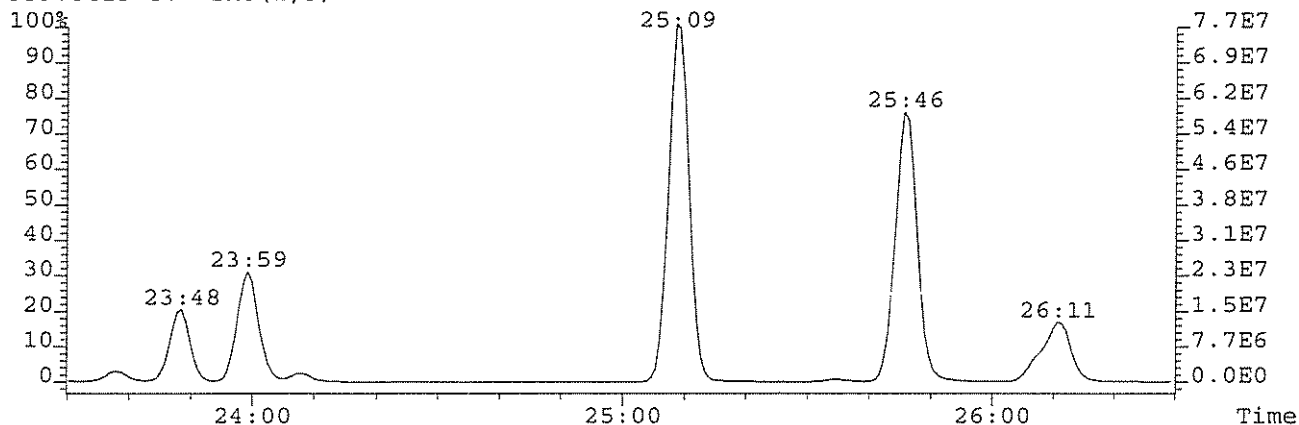
339.9178 S:7 SMO(1,3)



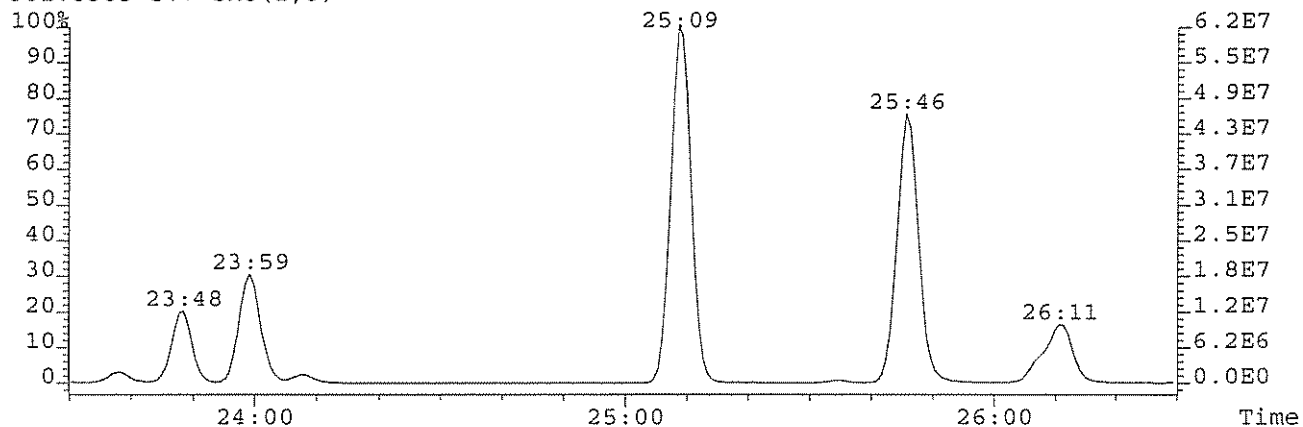
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130711-2 #1-2897 Acq:11-JUL-2013 22:03:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#7 File Text:RH-12ms(mP) Text:XE13 0948 2 Exp:RH-MP11

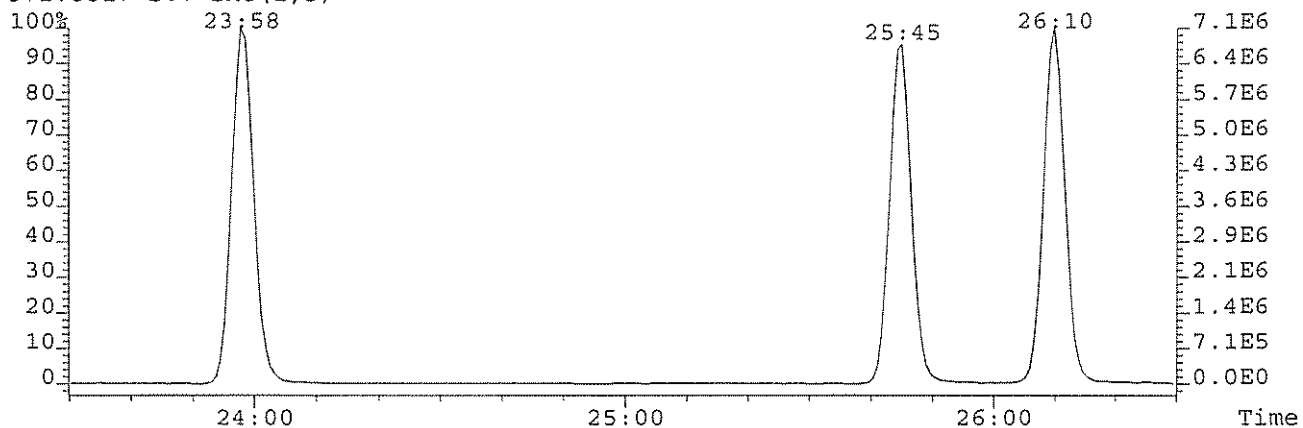
359.8415 S:7 SMO(1,3)



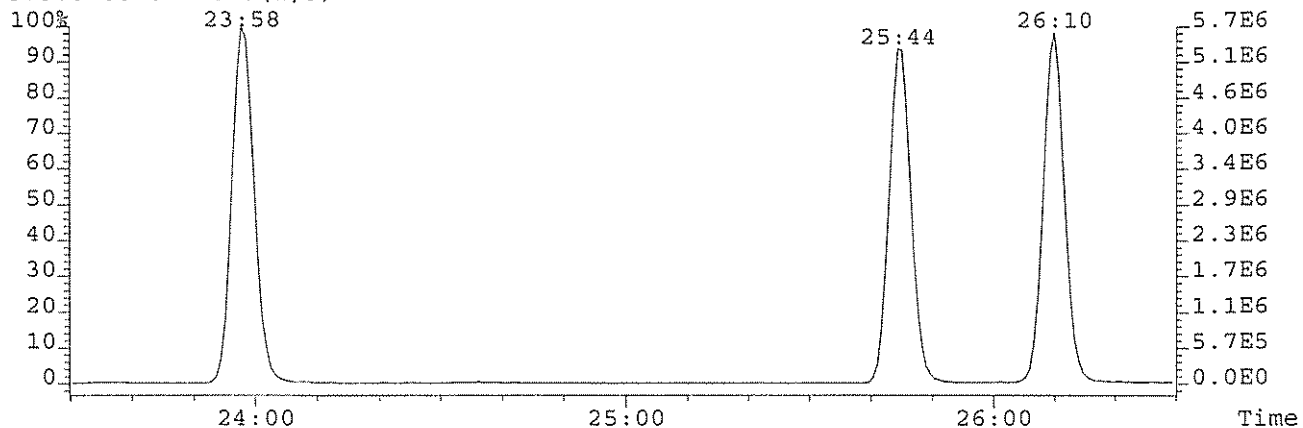
361.8385 S:7 SMO(1,3)



371.8817 S:7 SMO(1,3)

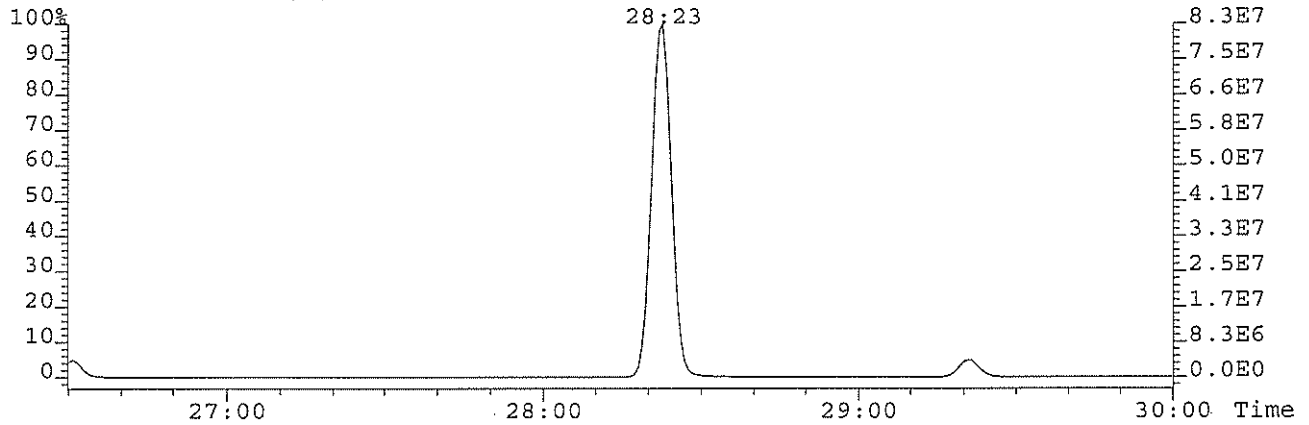


373.8788 S:7 SMO(1,3)

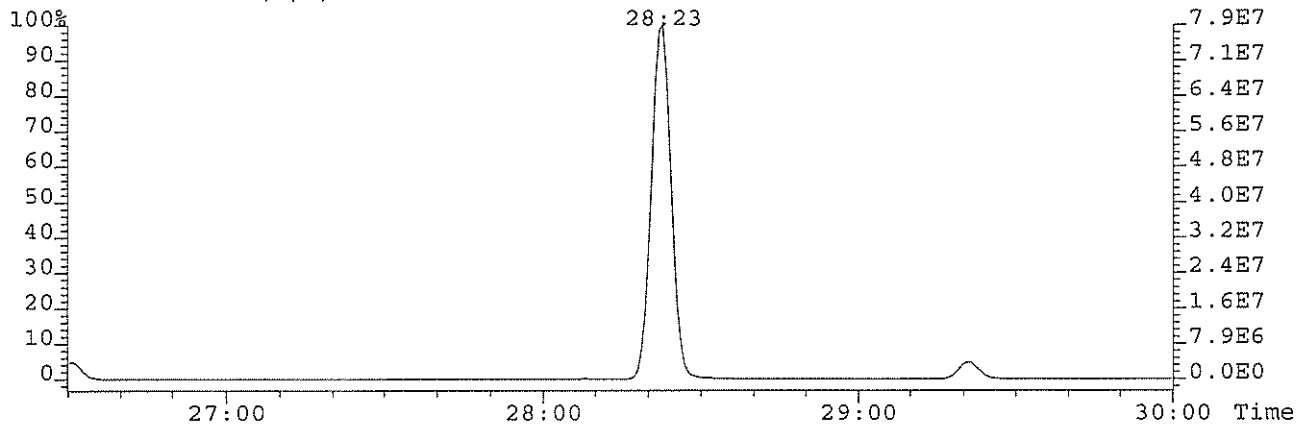


DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

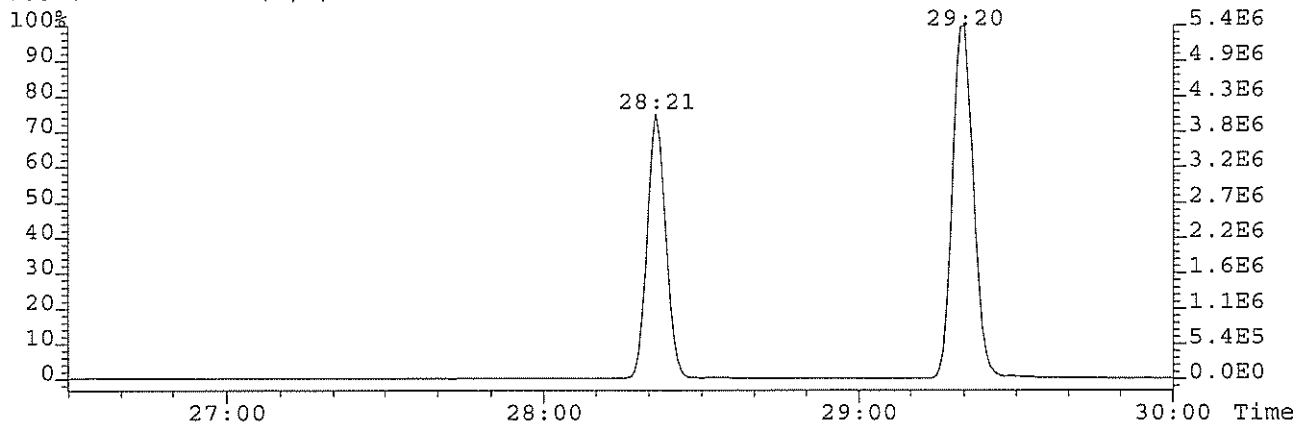
File:130711-2 #1-2897 Acq:11-JUL-2013 22:03:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#7 File Text:RH-12ms(mP) Text:XE13 0948 2 Exp:RH-MP11  
393.8025 S:7 SMO(1,3)



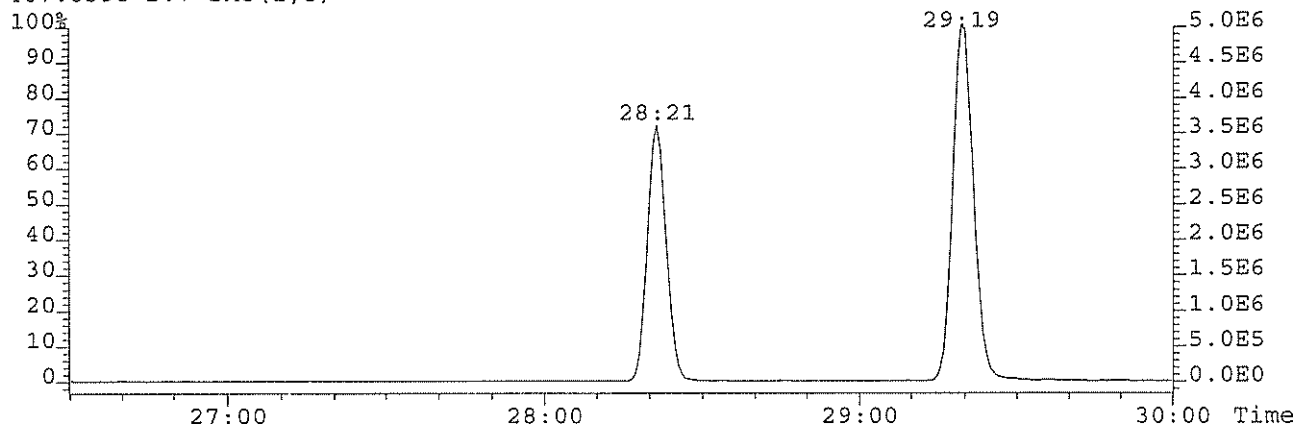
395.7995 S:7 SMO(1,3)



405.8428 S:7 SMO(1,3)



407.8398 S:7 SMO(1,3)

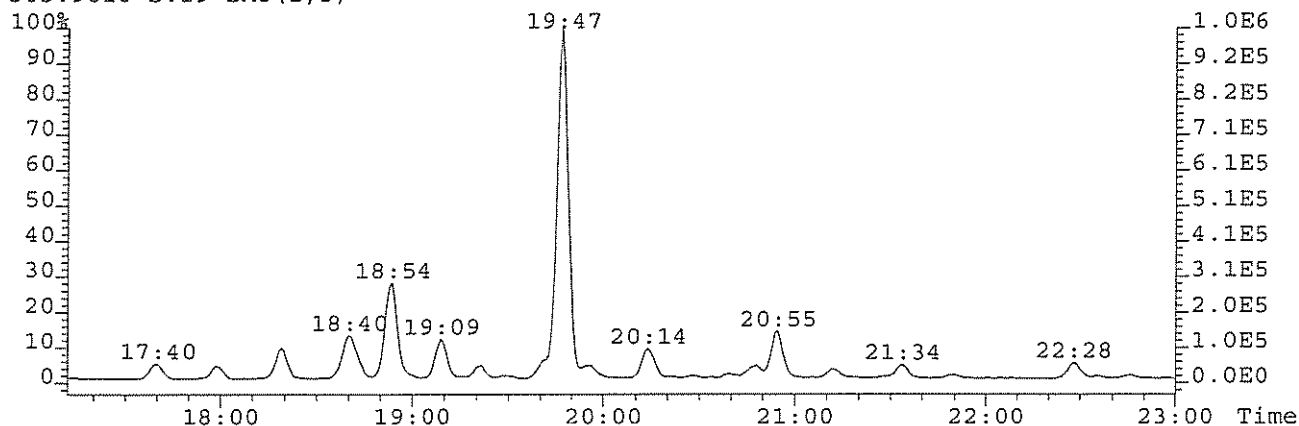


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

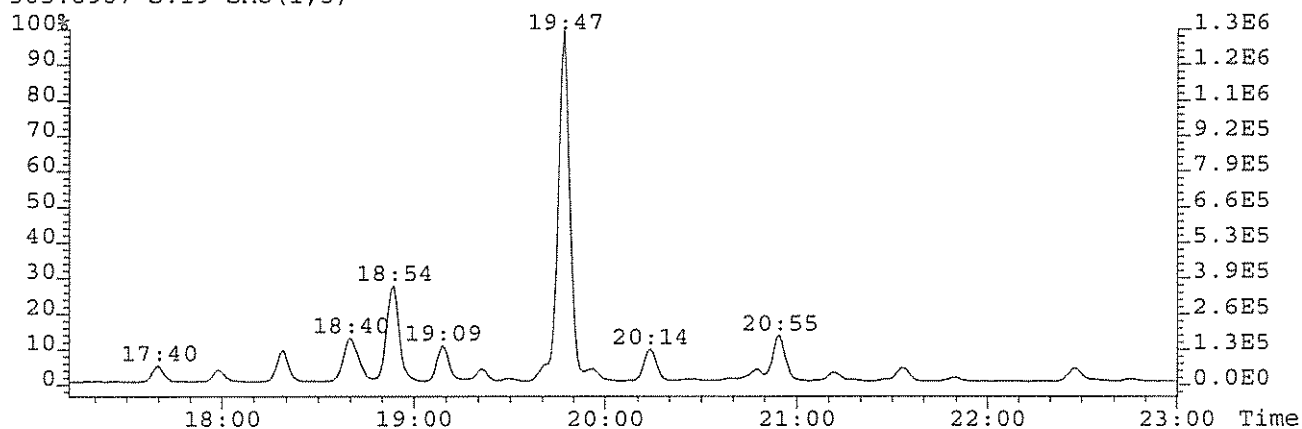
試料管理番号	XE 130949
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.3

File:130710-2 #1-1578 Acq:11-JUL-2013 05:48:18 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:BPX-DXN(4-6DXN) Text:XE13 0949 Exp:BPX04

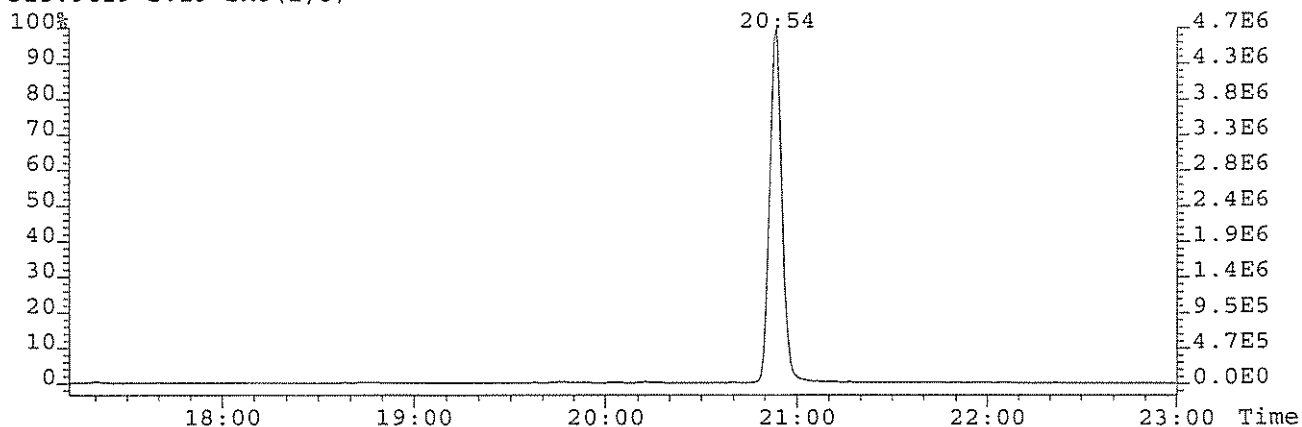
303.9016 S:19 SMO(1,3)



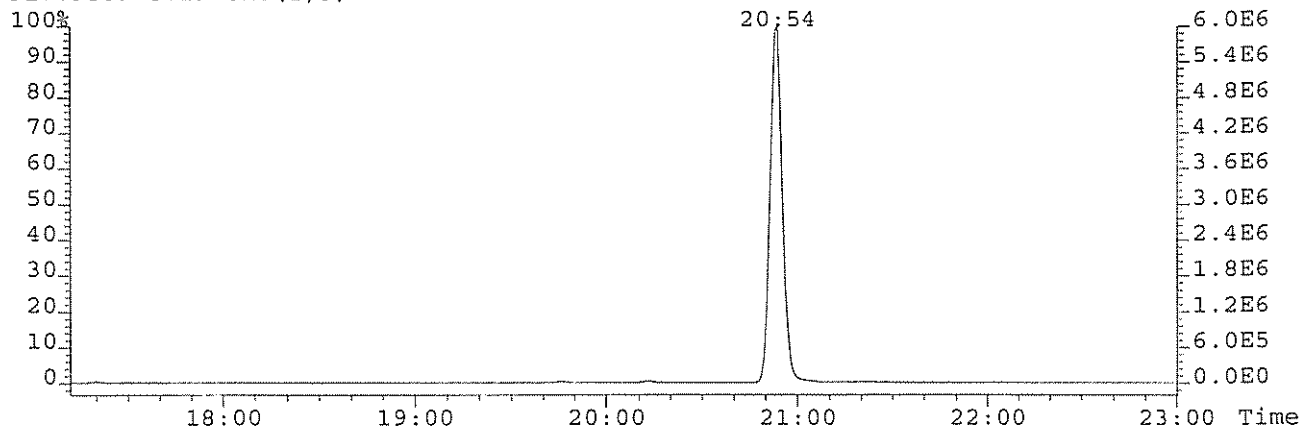
305.8987 S:19 SMO(1,3)



315.9419 S:19 SMO(1,3)

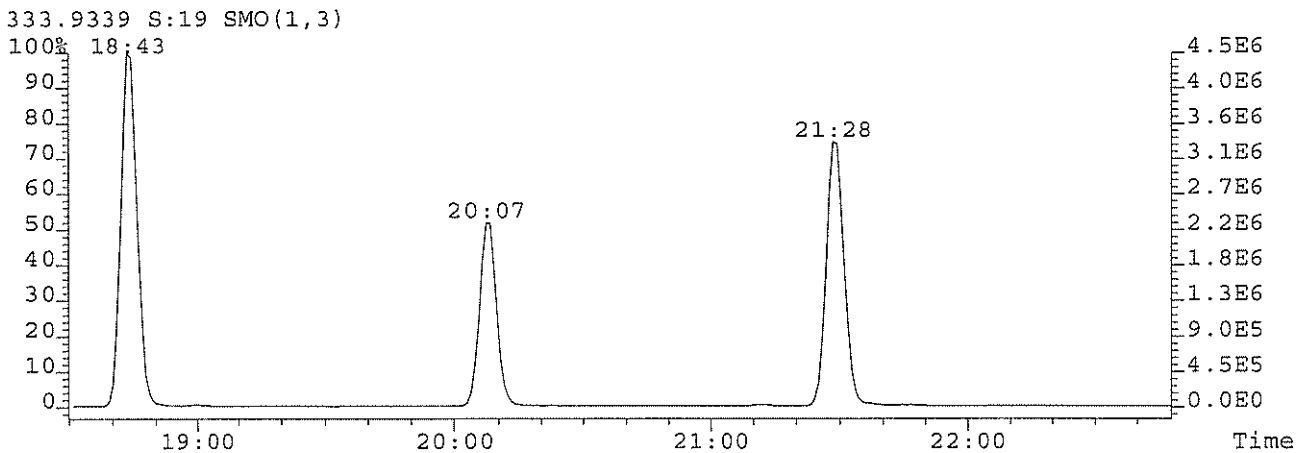
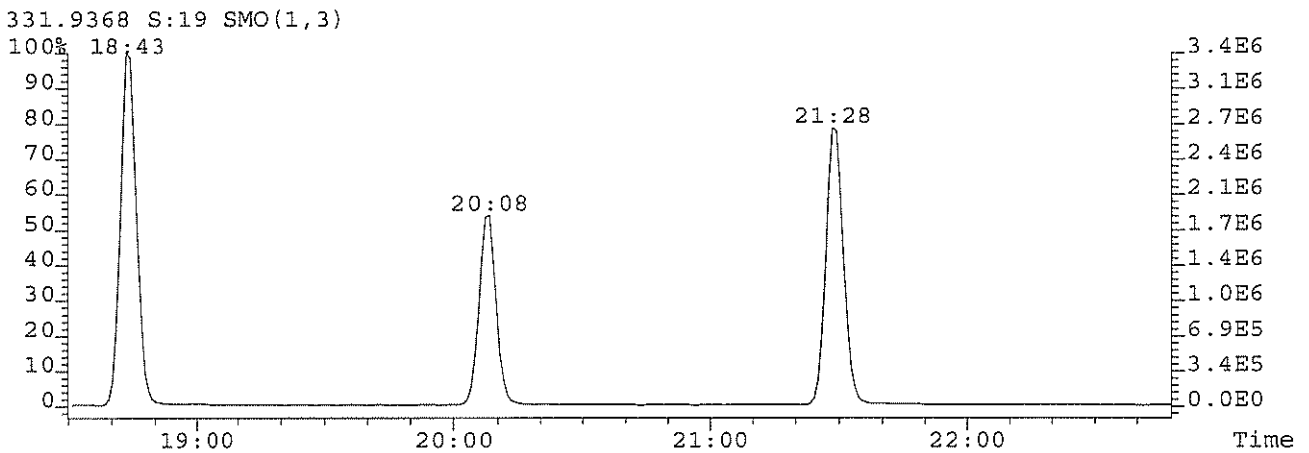
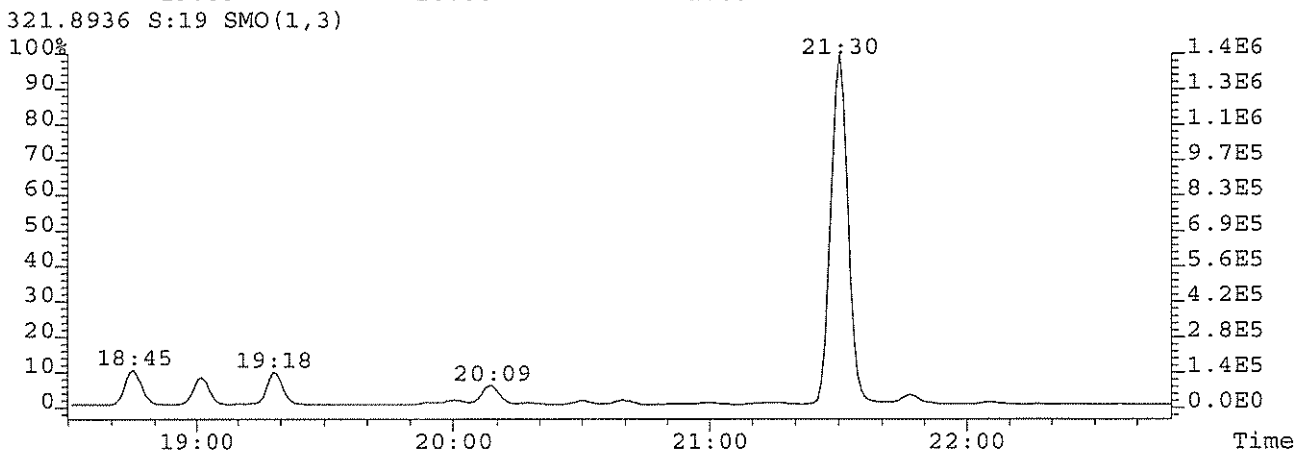
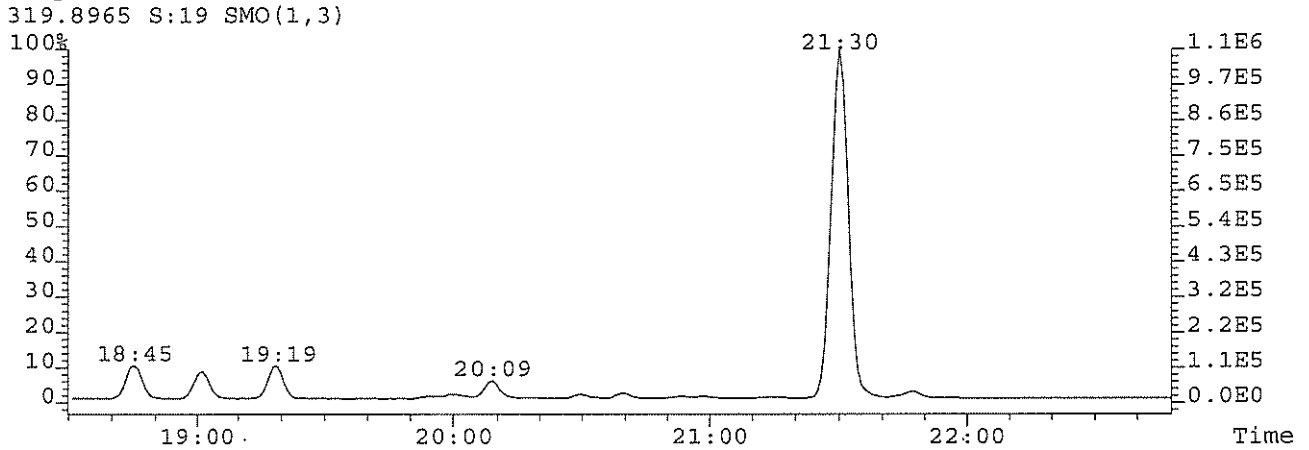


317.9389 S:19 SMO(1,3)



PCDFsクロマトグラム (1)  
(TeCDFs)

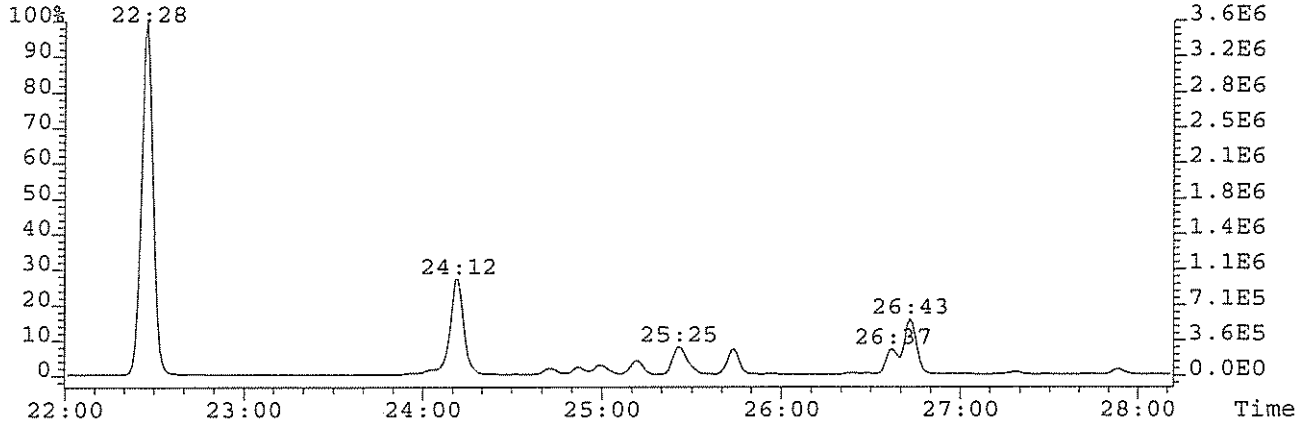
File:130710-2 #1-1578 Acq:11-JUL-2013 05:48:18 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:BPX-DXN(4-6DXN) Text:XE13 0949 Exp:BPX04



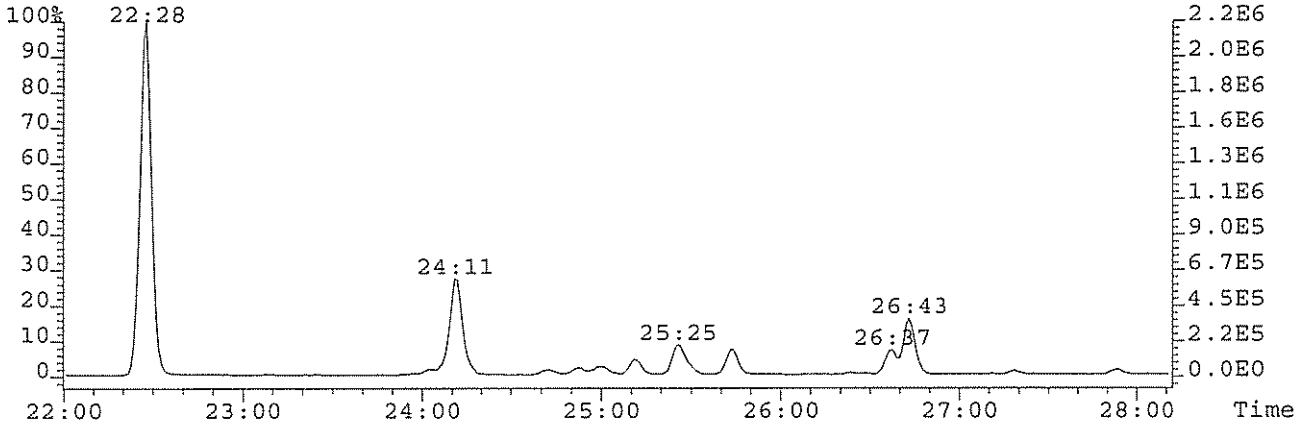
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130710-2 #1-1578 Acq:11-JUL-2013 05:48:18 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:BPX-DXN(4-6DXN) Text:XE13 0949 Exp:BPX04

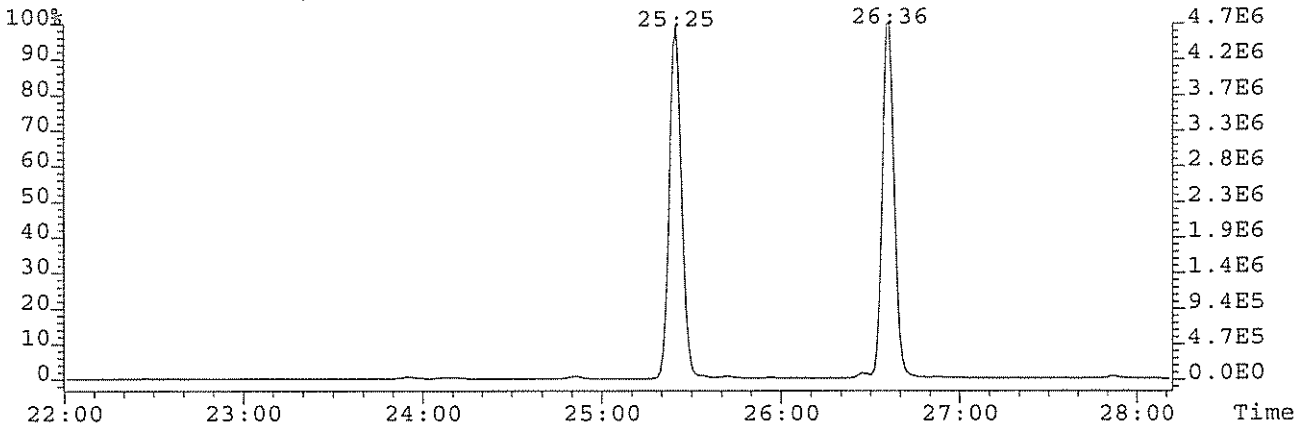
339.8597 S:19 SMO(1,3)



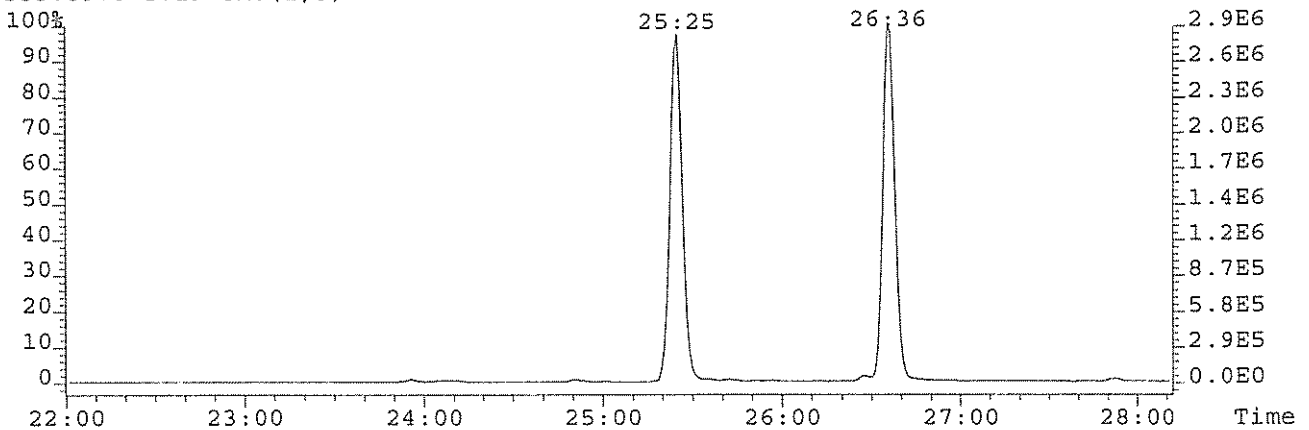
341.8568 S:19 SMO(1,3)



351.9000 S:19 SMO(1,3)



353.8970 S:19 SMO(1,3)

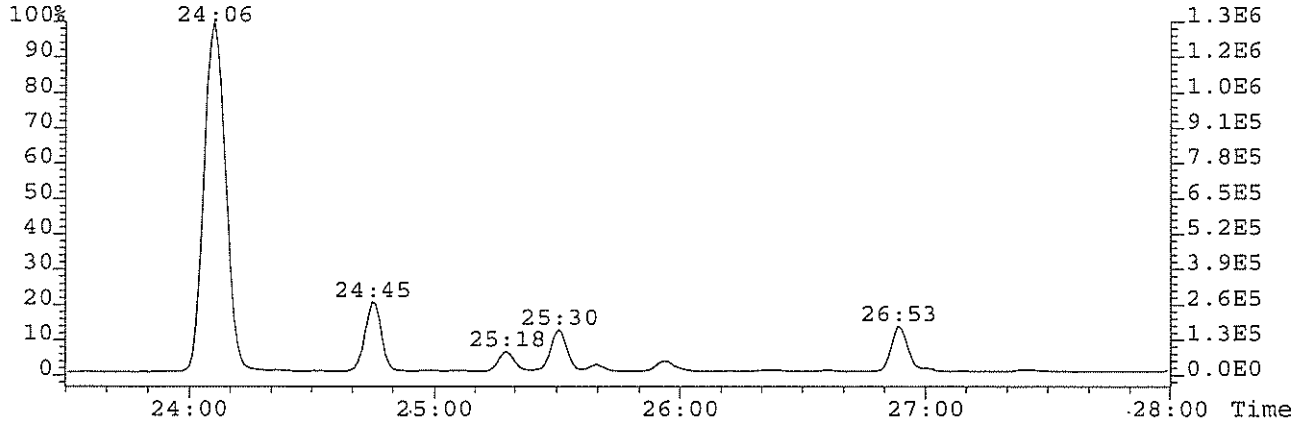


PCDFsクロマトグラム (3)  
(PeCDFs)

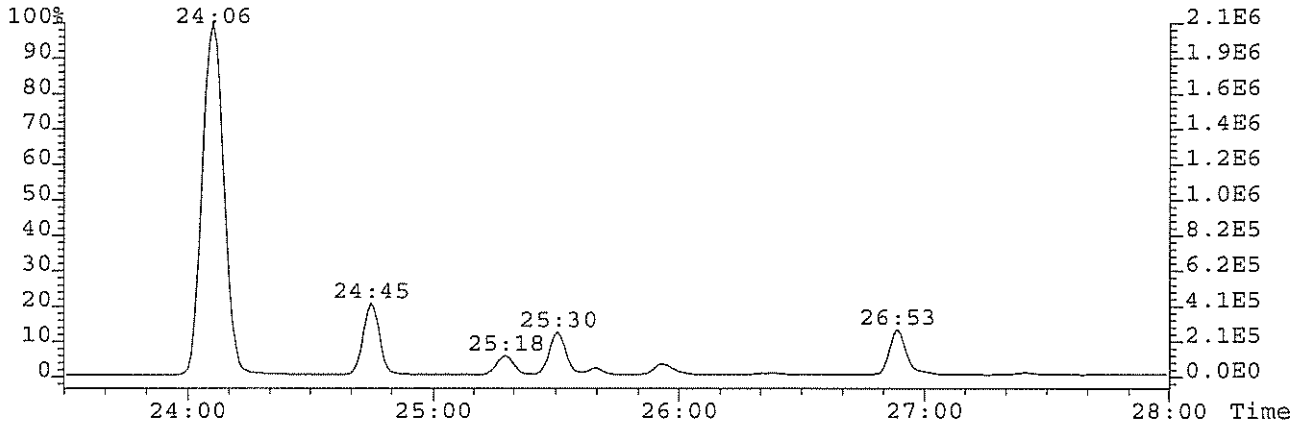


File:130710-2 #1-1578 Acq:11-JUL-2013 05:48:18 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:BPX-DXN(4-6DXN) Text:XE13 0949 Exp:BPX04

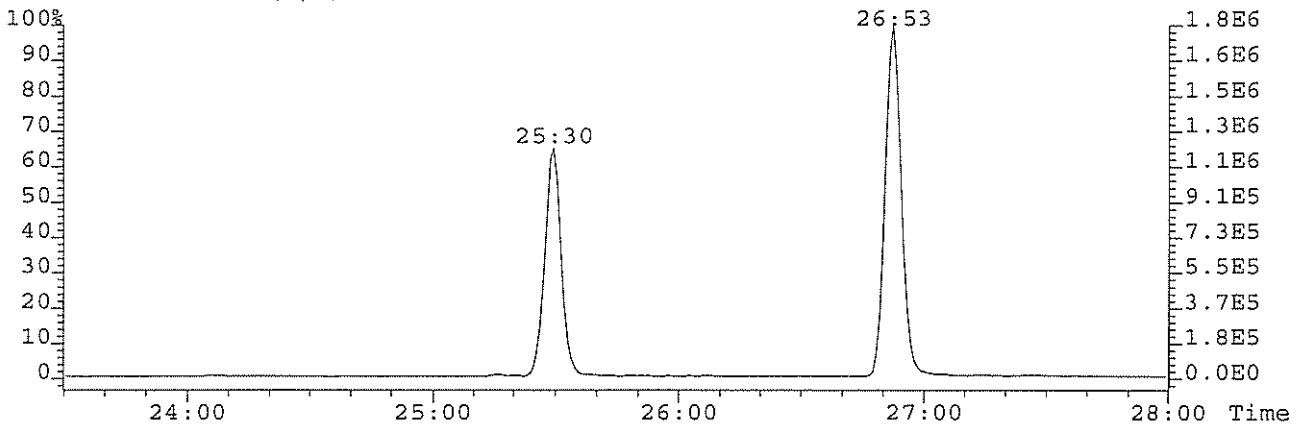
353.8576 S:19 SMO(1,3)



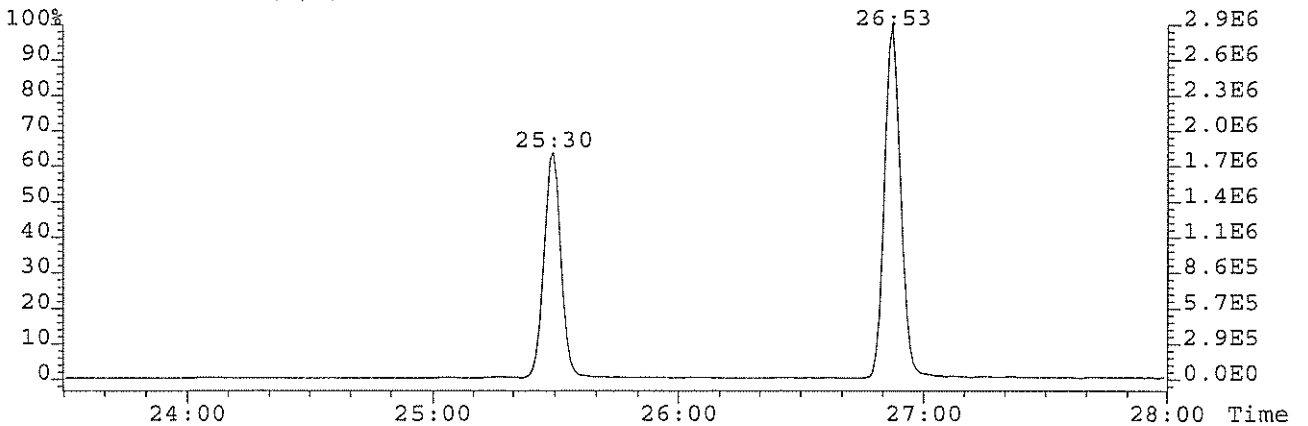
355.8546 S:19 SMO(1,3)



365.8978 S:19 SMO(1,3)

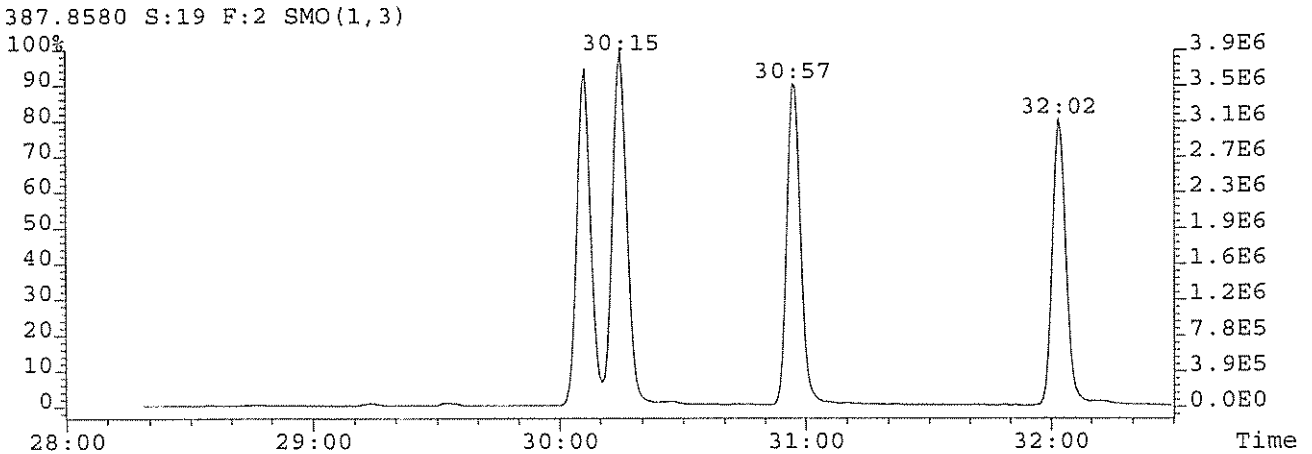
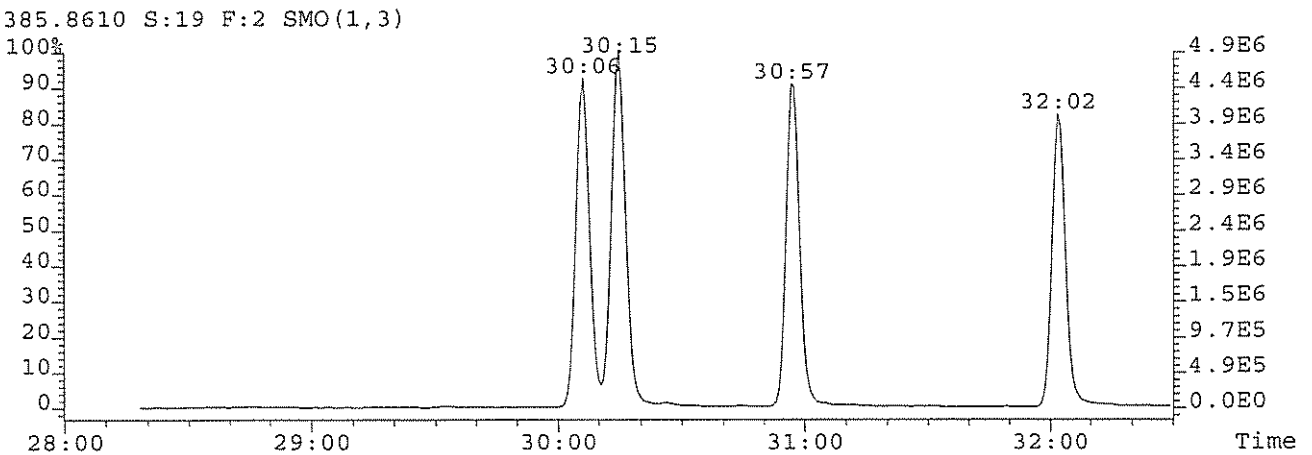
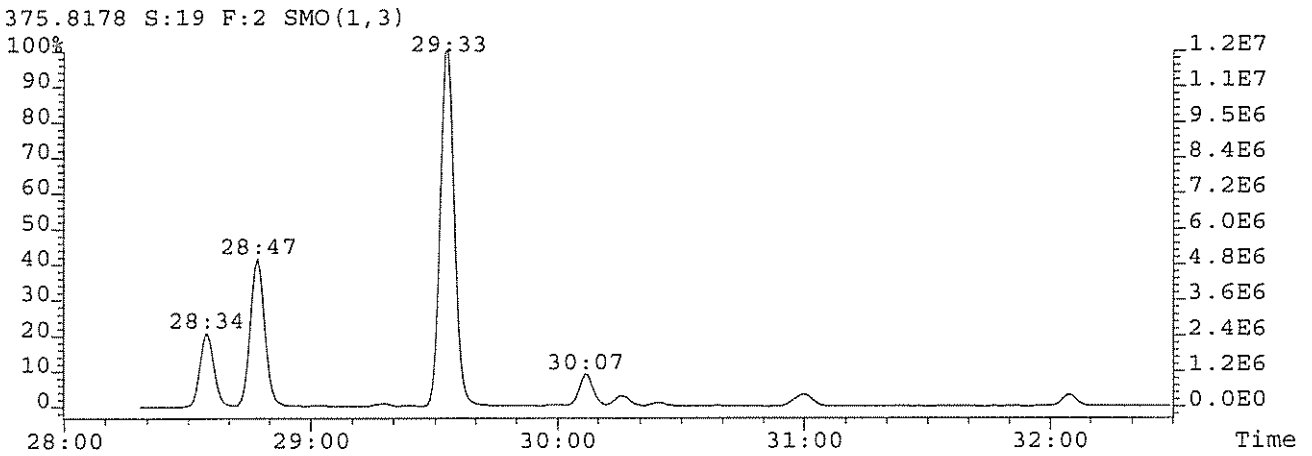
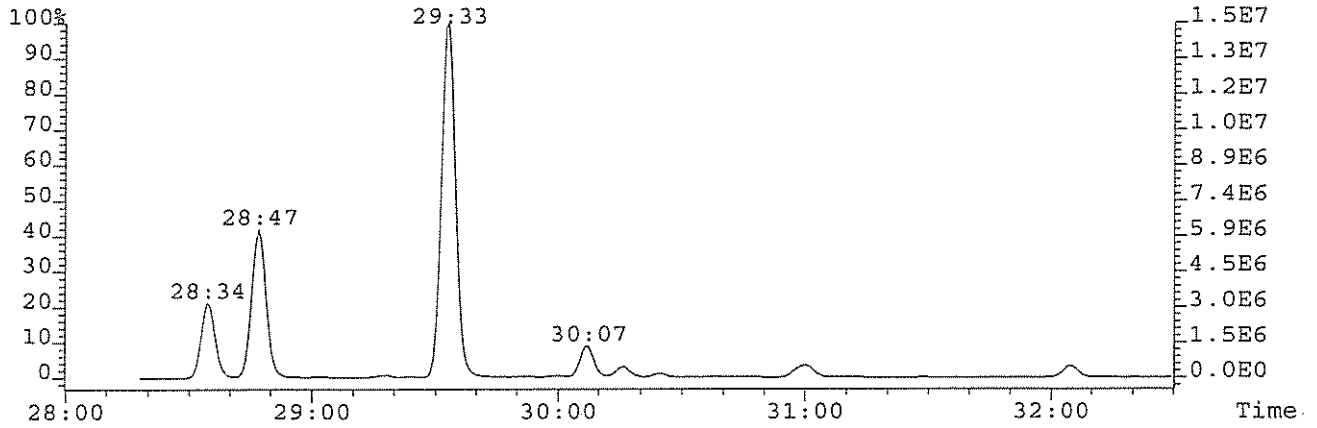


367.8949 S:19 SMO(1,3)



PCDDsクロマトグラム (4)  
(PeCDDs)

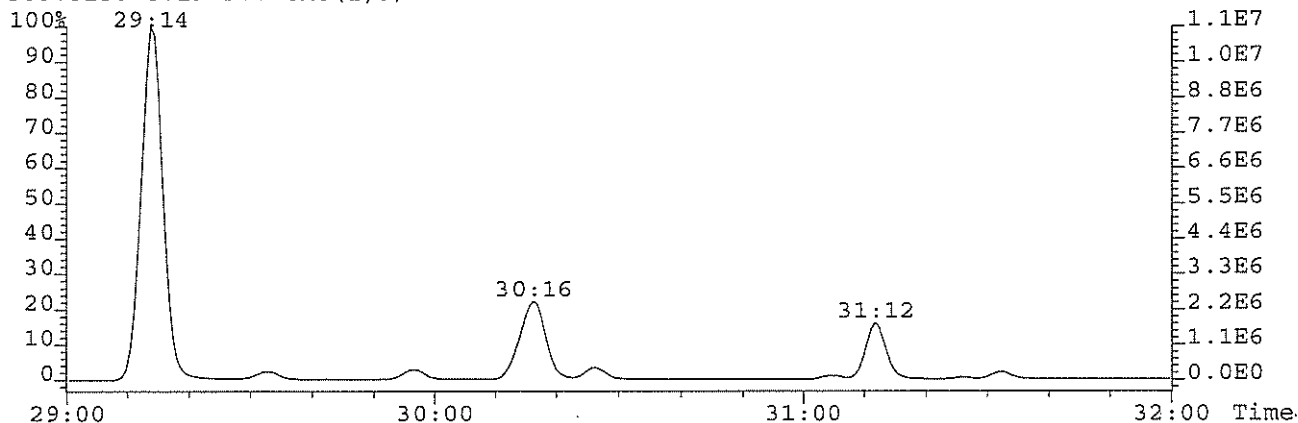
File:130710-2 #1-1117 Acq:11-JUL-2013 05:48:18 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:BPX-DXN(4-6DXN) Text:XE13 0949 Exp:BPX04  
373.8207 S:19 F:2 SMO(1,3)



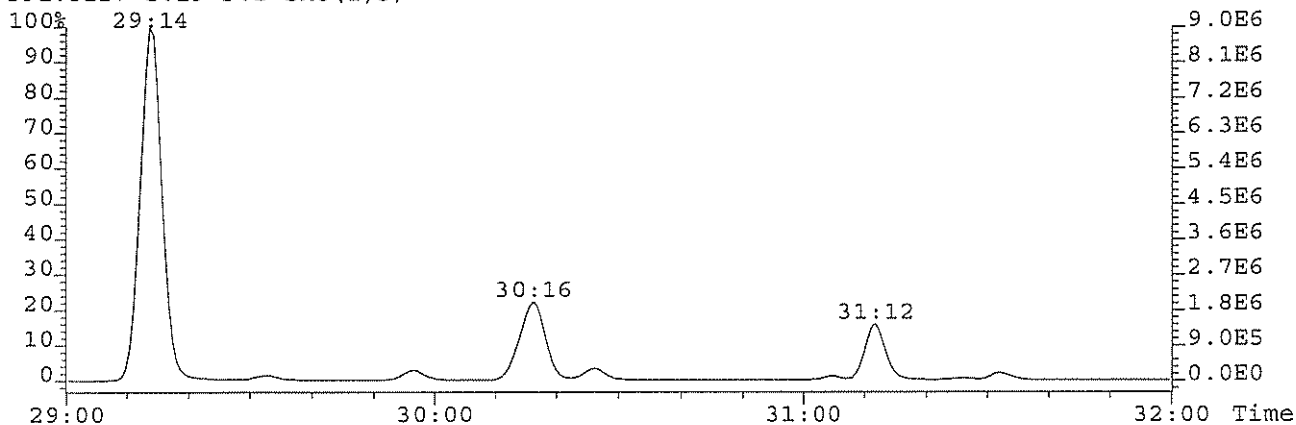
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130710-2 #1-1117 Acq:11-JUL-2013 05:48:18 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:BPX-DXN(4-6DXN) Text:XE13 0949 Exp:BPX04

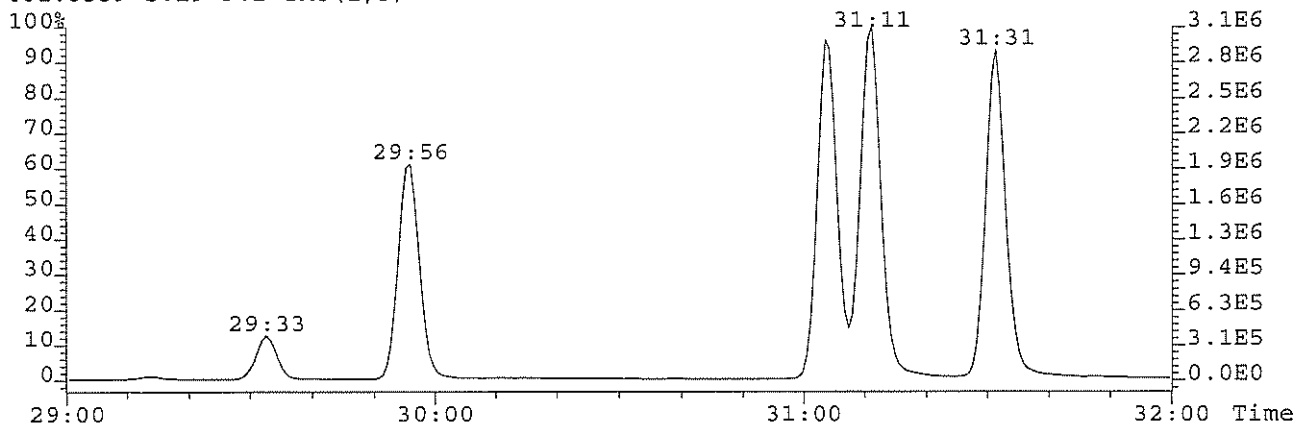
389.8156 S:19 F:2 SMO(1,3)



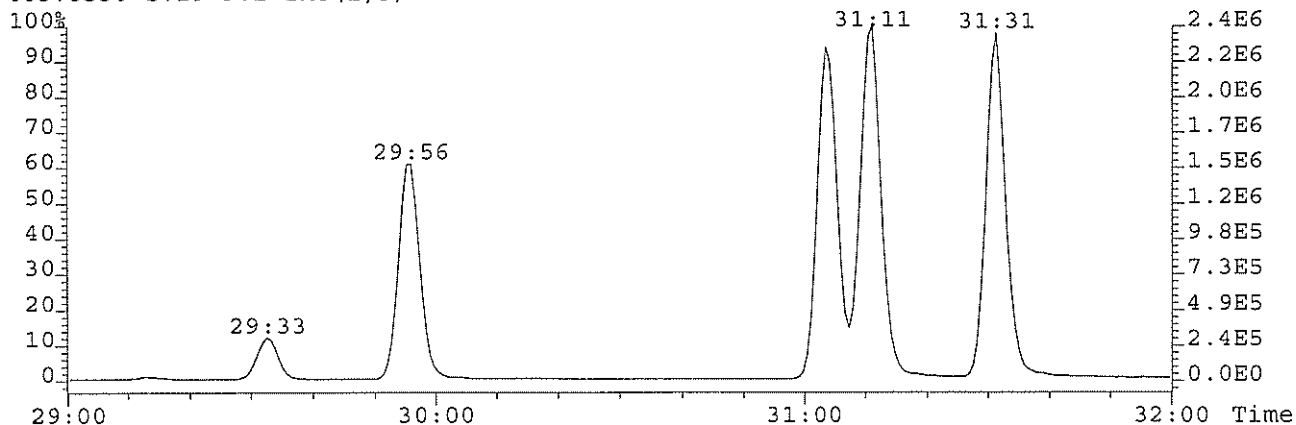
391.8127 S:19 F:2 SMO(1,3)



401.8559 S:19 F:2 SMO(1,3)

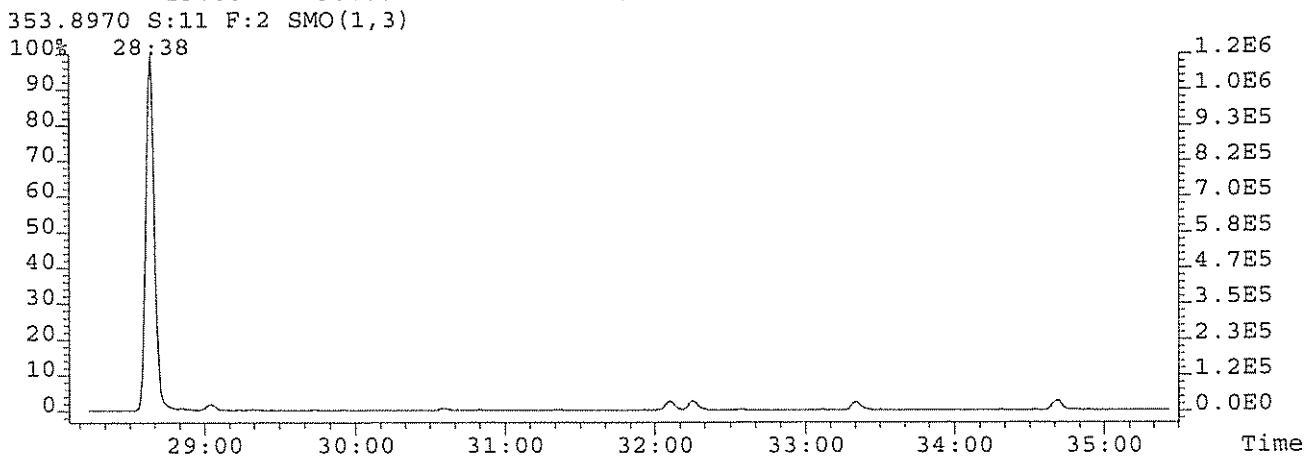
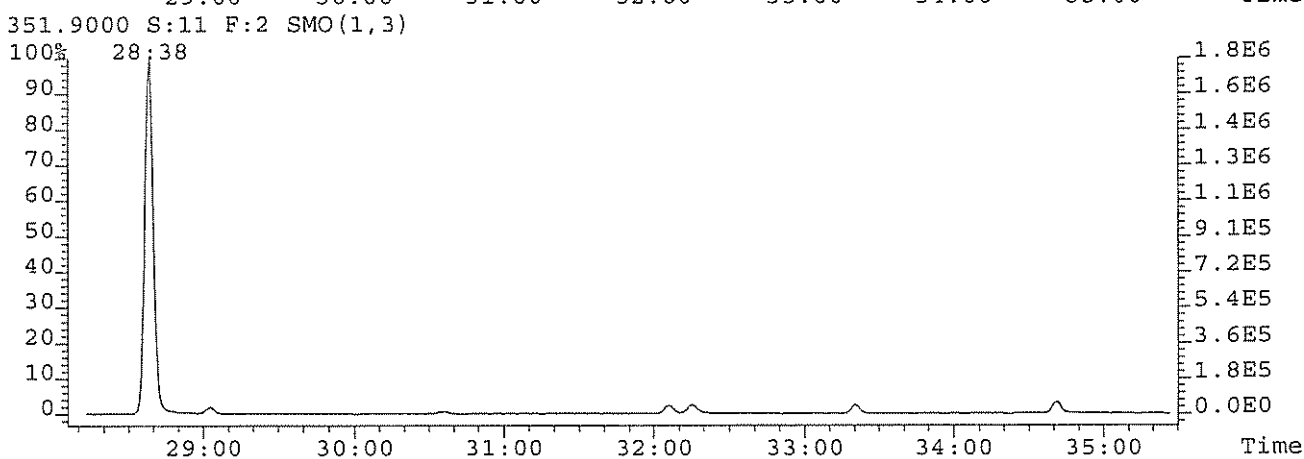
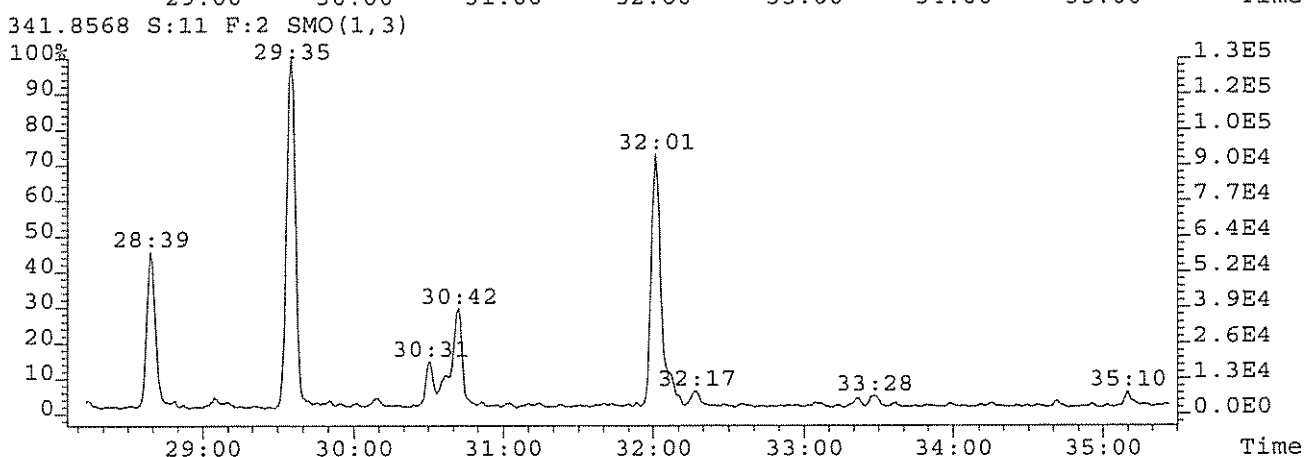
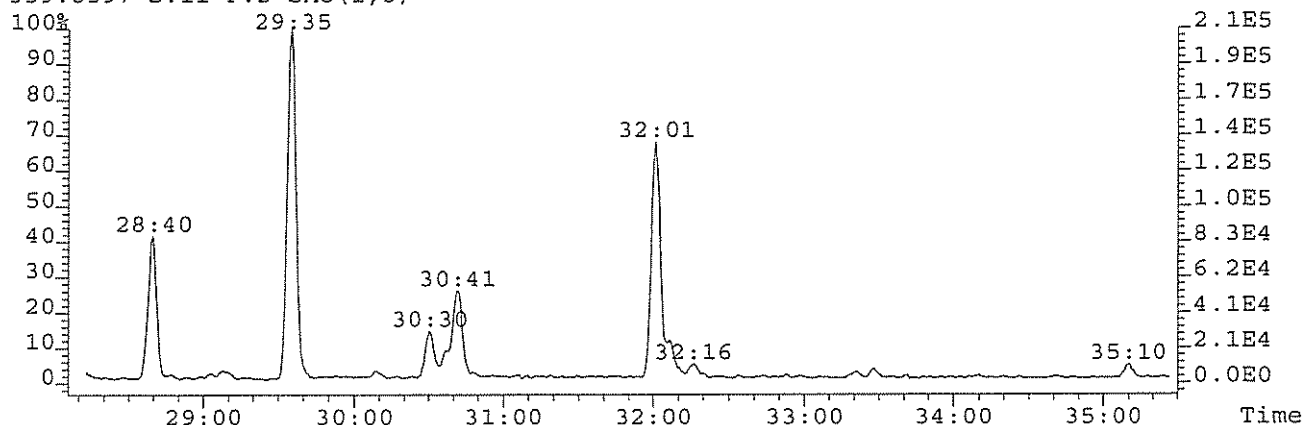


403.8530 S:19 F:2 SMO(1,3)



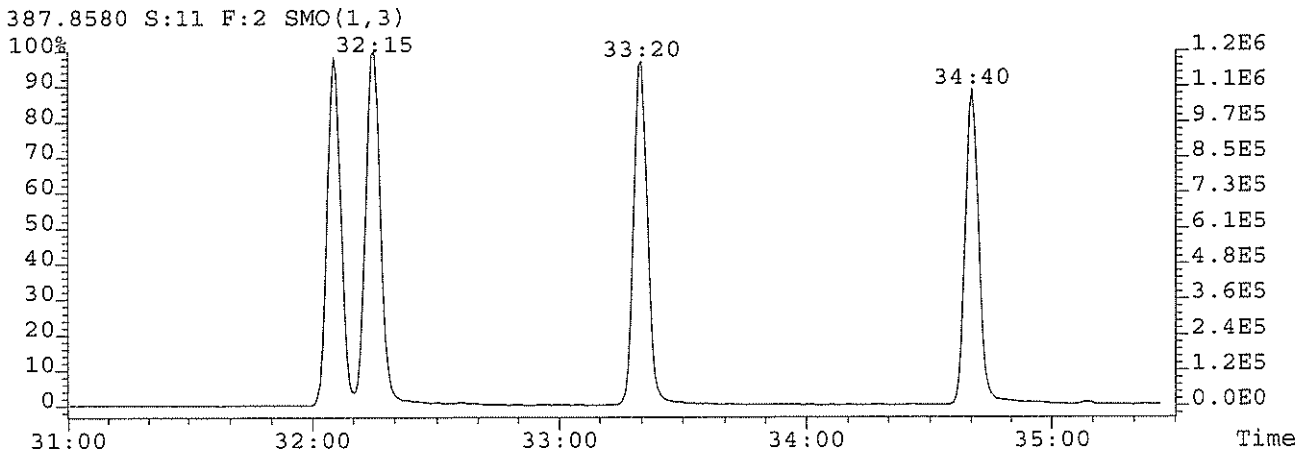
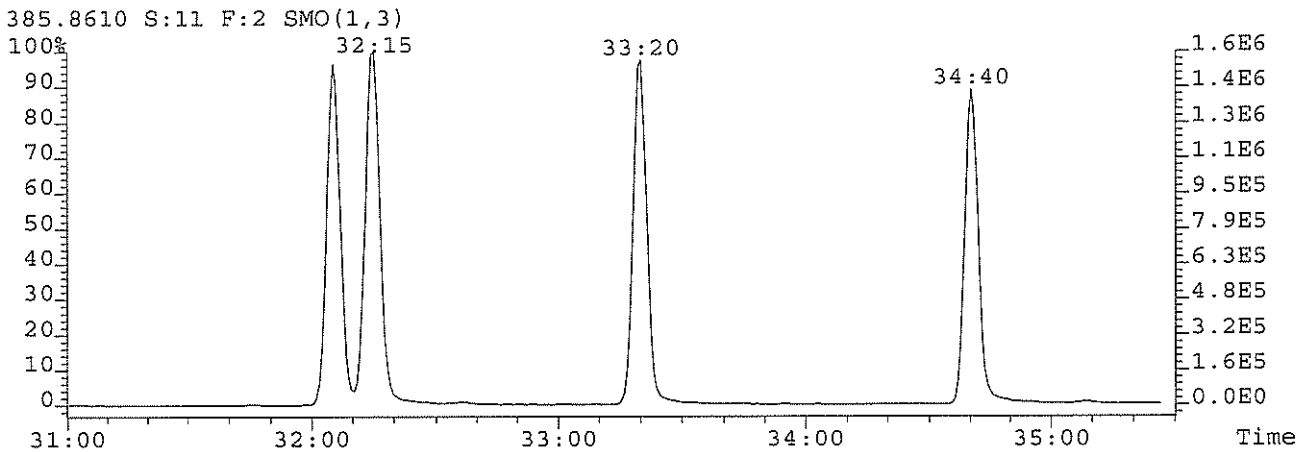
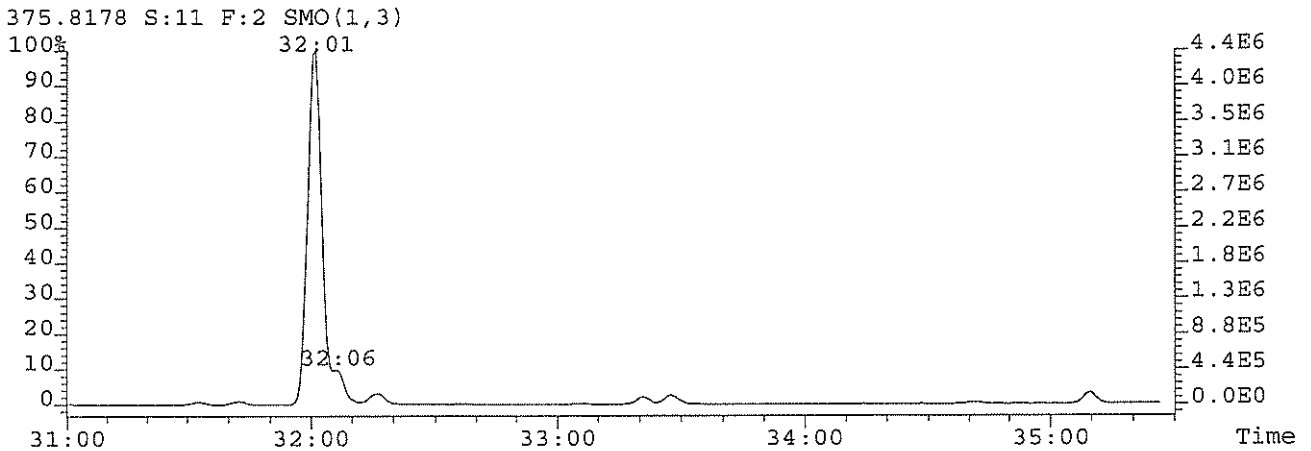
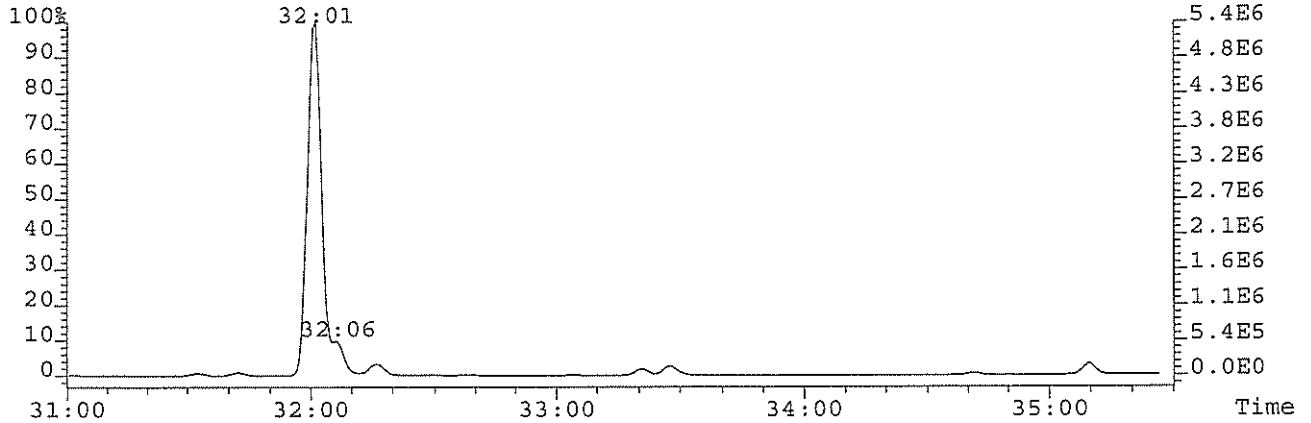
PCDDsクロマトグラム (6)  
(HxCDDs)

File:130711-2 #1-649 Acq:12-JUL-2013 03:08:31 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(5-8,nP) Text:XE13 0949 3 Exp:RH-PD22  
339.8597 S:11 F:2 SMO(1,3)



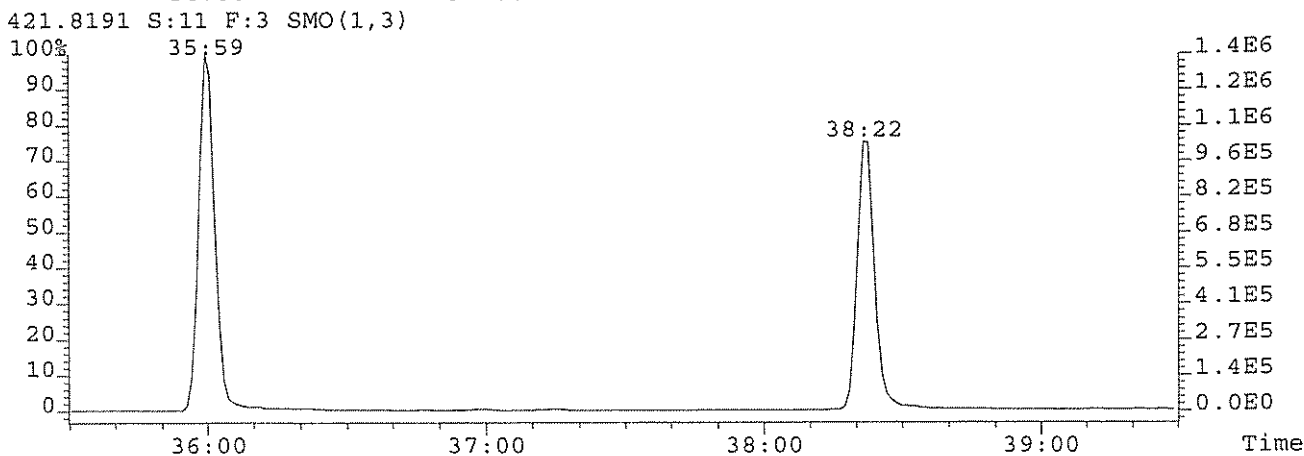
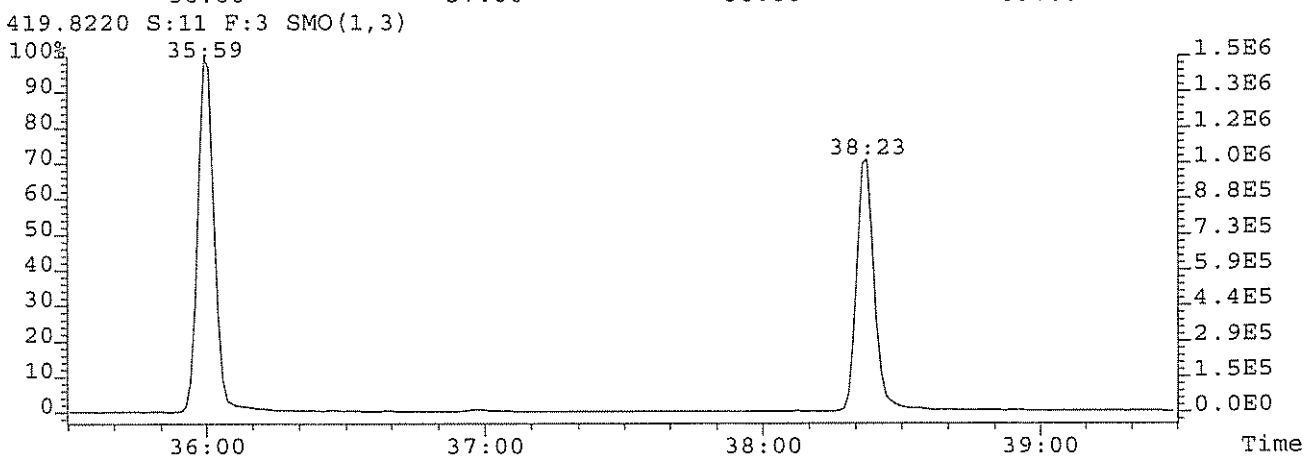
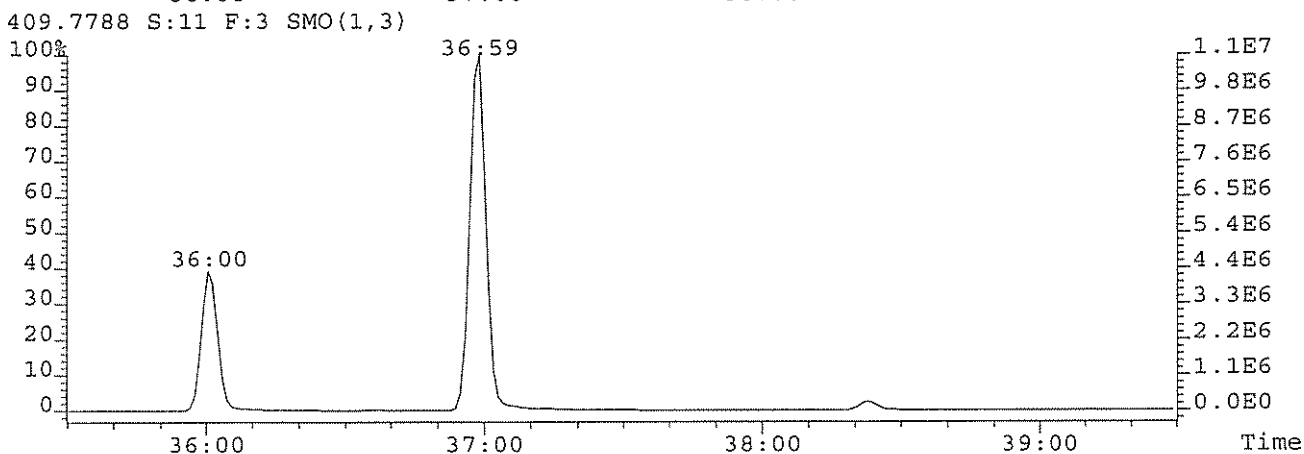
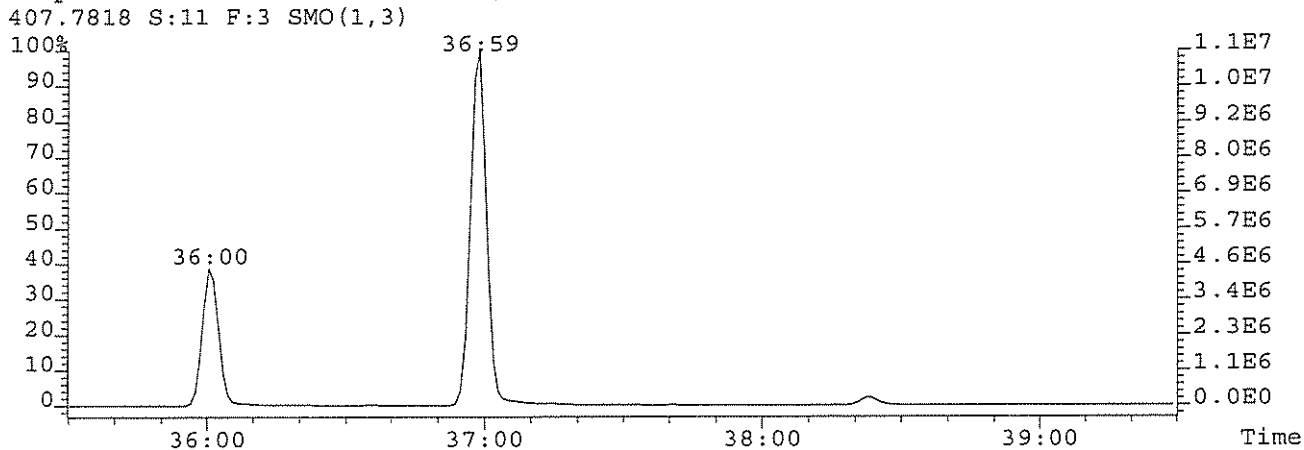
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130711-2 #1-649 Acq:12-JUL-2013 03:08:31 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(5-8,nP) Text:XE13 0949 3 Exp:RH-PD22  
373.8207 S:11 F:2 SMO(1,3)



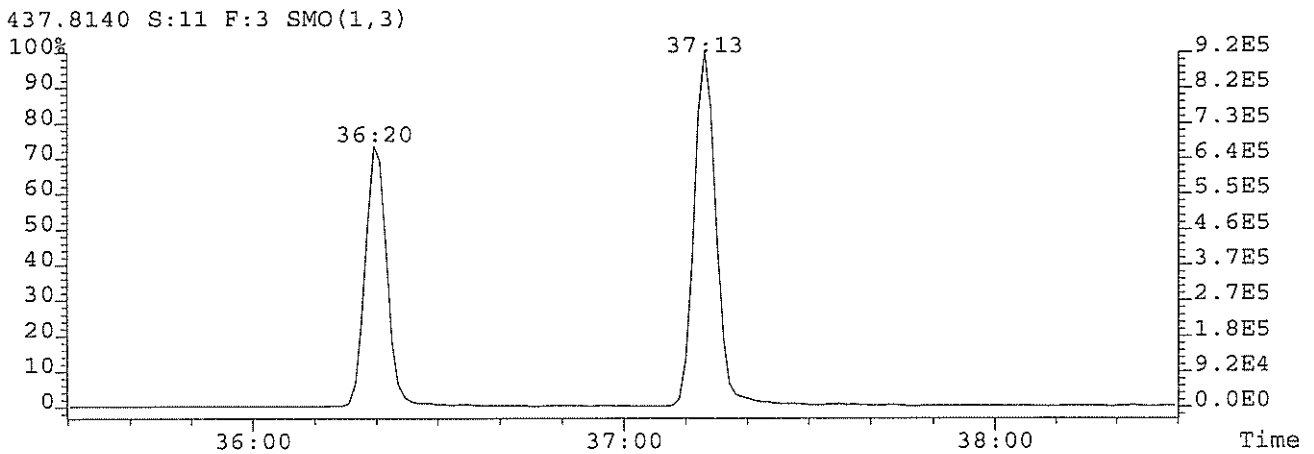
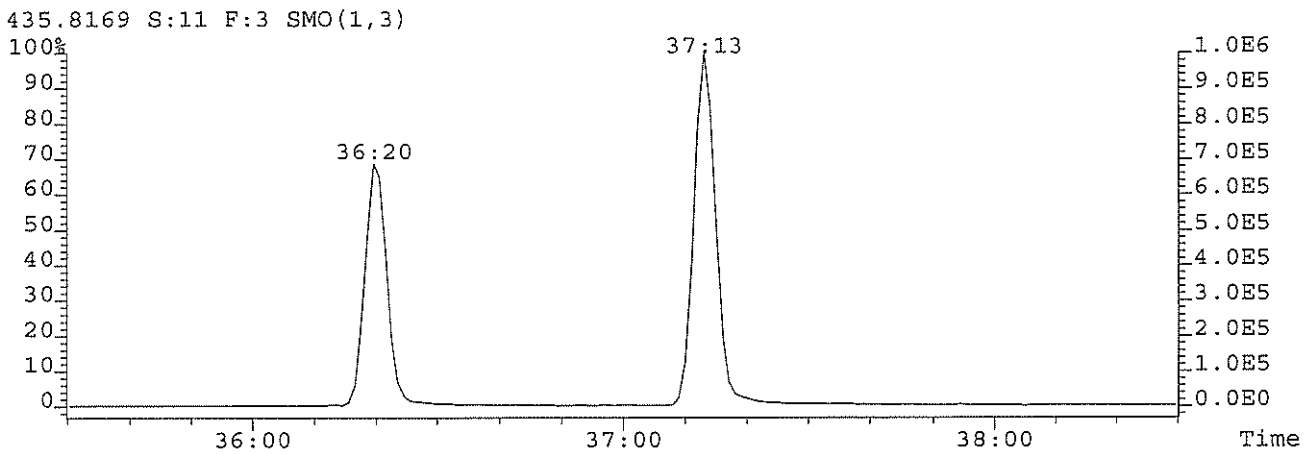
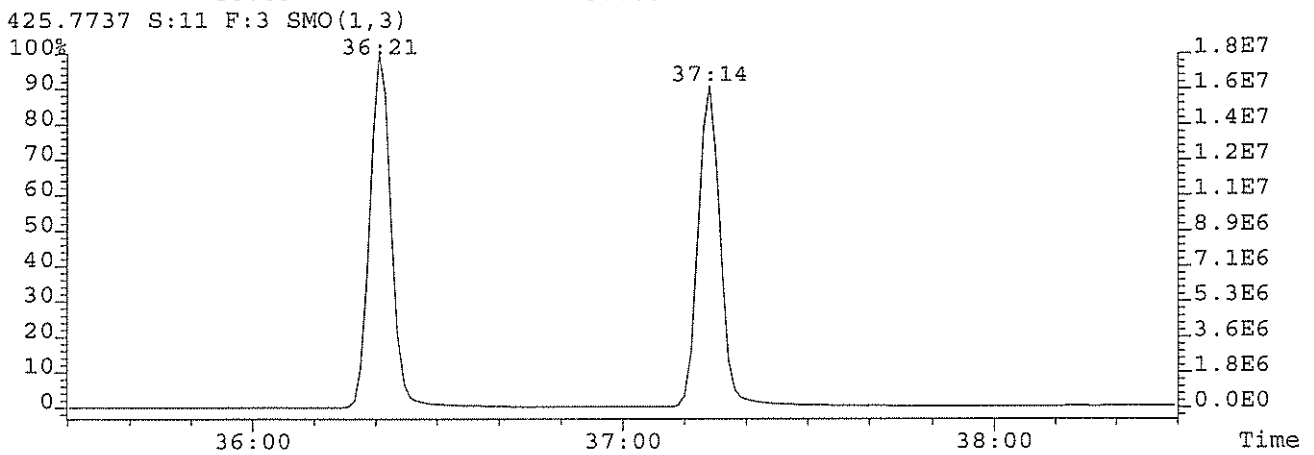
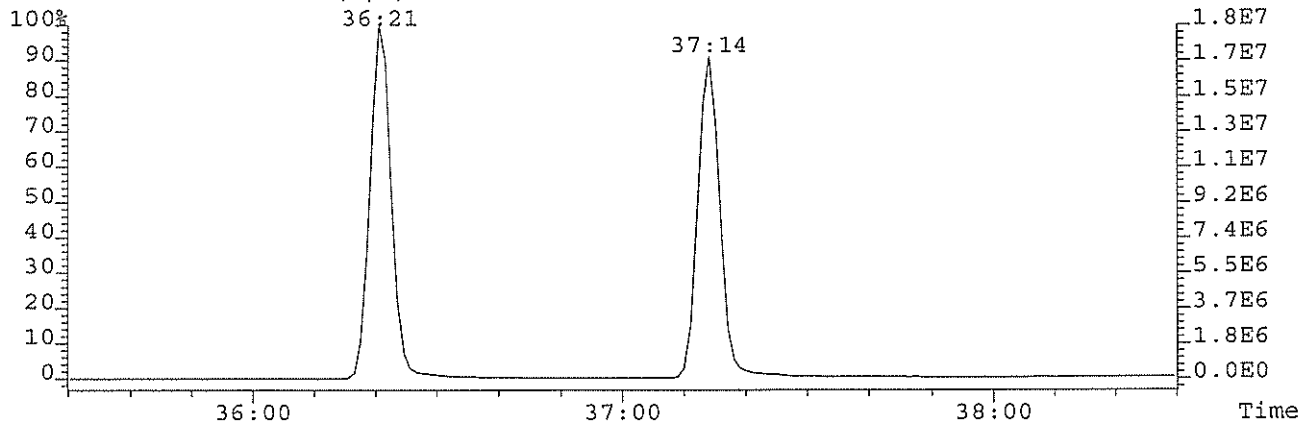
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130711-2 #1-562 Acq:12-JUL-2013 03:08:31 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(5-8,nP) Text:XE13 0949 3 Exp:RH-PD22



PCDFsクロマトグラム (9)  
(HpCDFs)

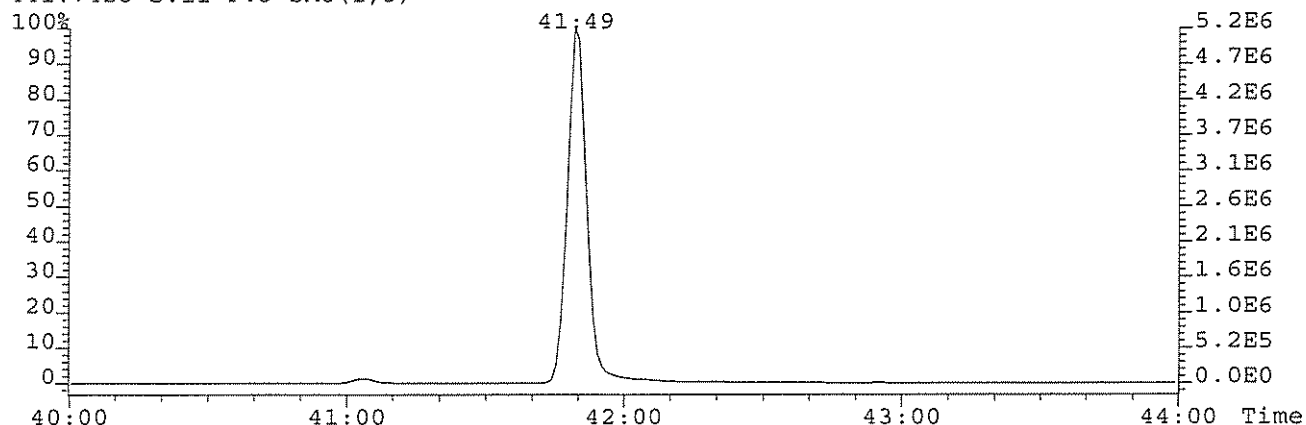
File:130711-2 #1-562 Acq:12-JUL-2013 03:08:31 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(5-8,nP) Text:XE13 0949 3 Exp:RH-PD22  
423.7767 S:11 F:3 SMO(1,3)



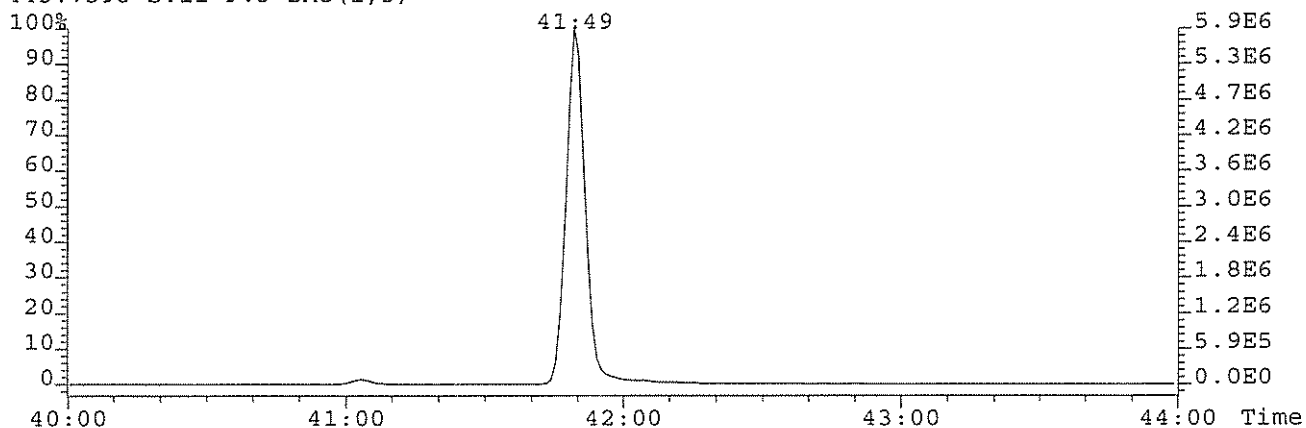
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130711-2 #1-562 Acq:12-JUL-2013 03:08:31 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(5-8,nP) Text:XE13 0949 3 Exp:RH-PD22

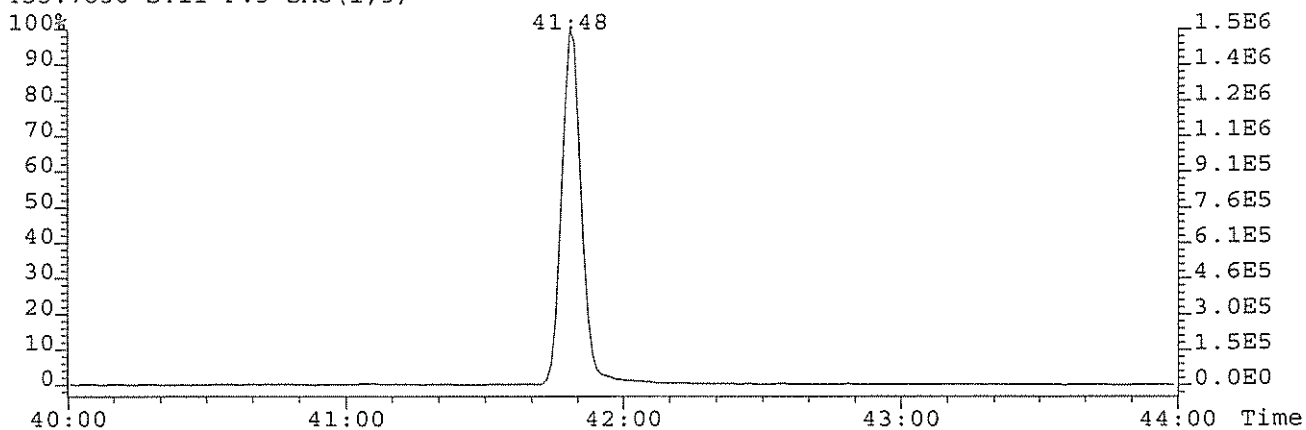
441.7428 S:11 F:3 SMO(1,3)



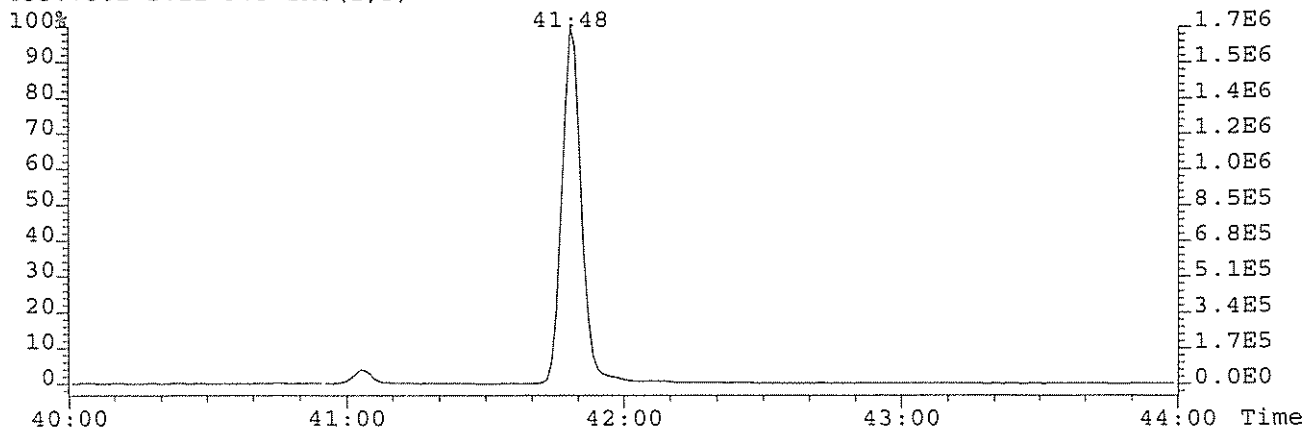
443.7398 S:11 F:3 SMO(1,3)



453.7830 S:11 F:3 SMO(1,3)



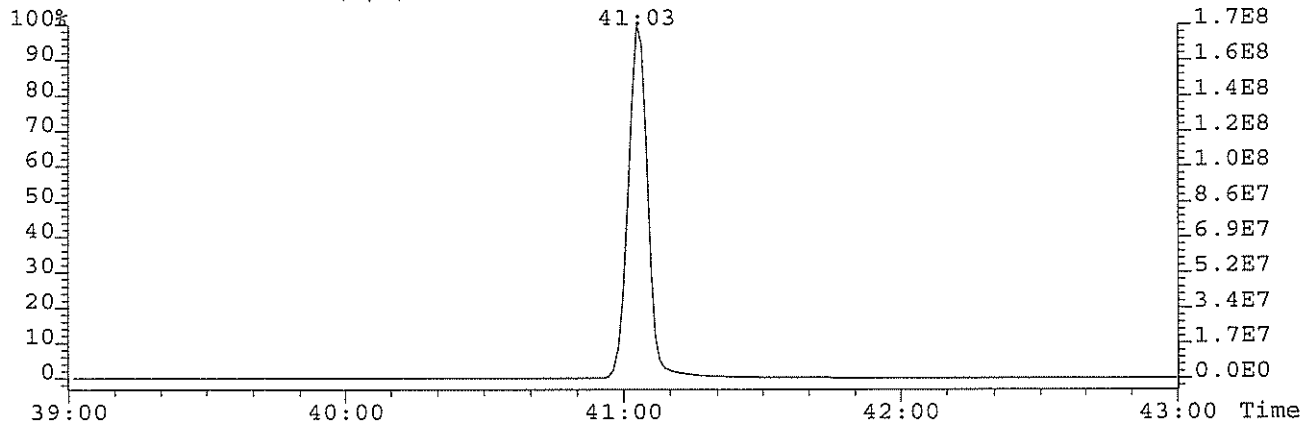
455.7801 S:11 F:3 SMO(1,3)



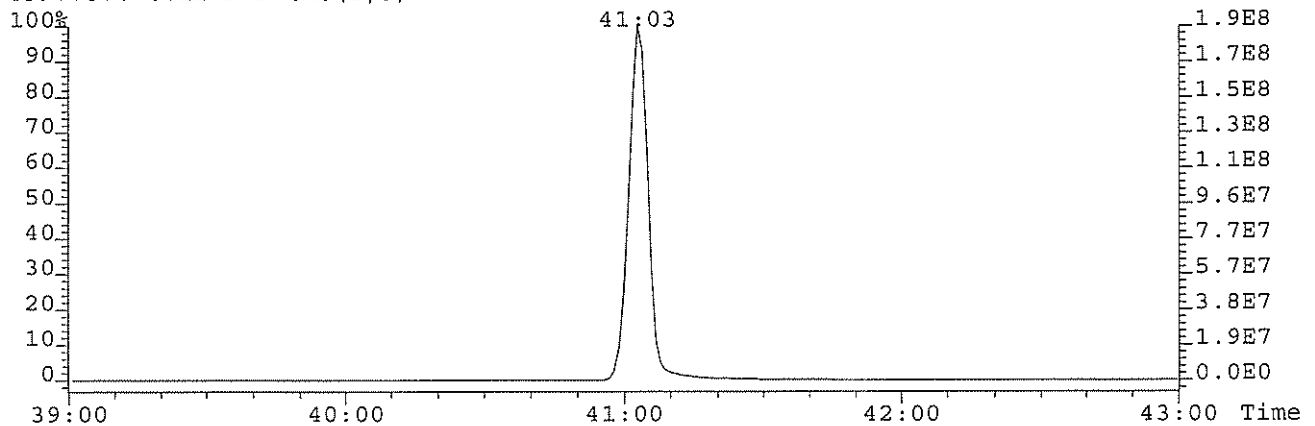
PCDFsクロマトグラム (11)  
(OCDF)



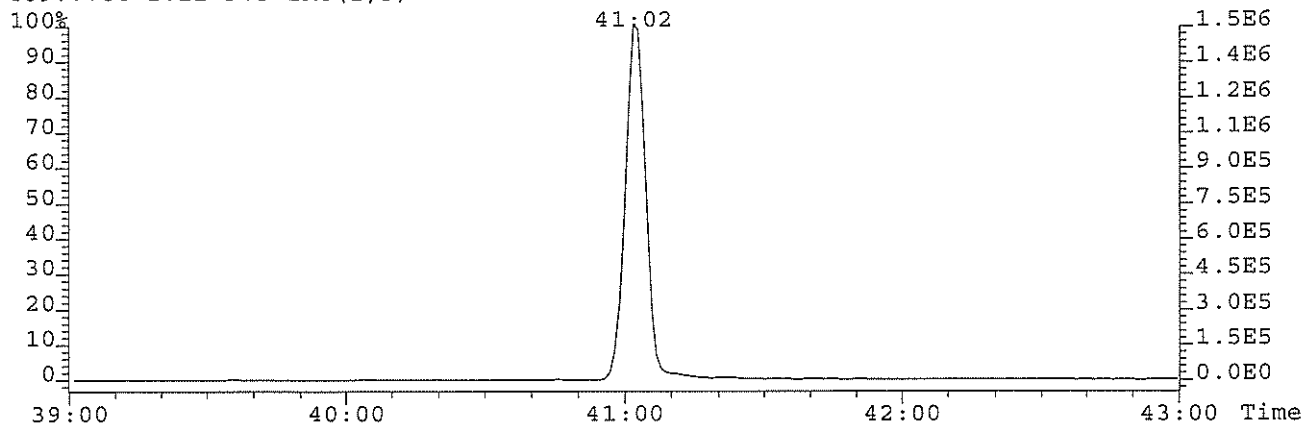
File:130711-2 #1-562 Acq:12-JUL-2013 03:08:31 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(5-8,nP) Text:XE13 0949 3 Exp:RH-PD22  
457.7377 S:11 F:3 SMO(1,3)



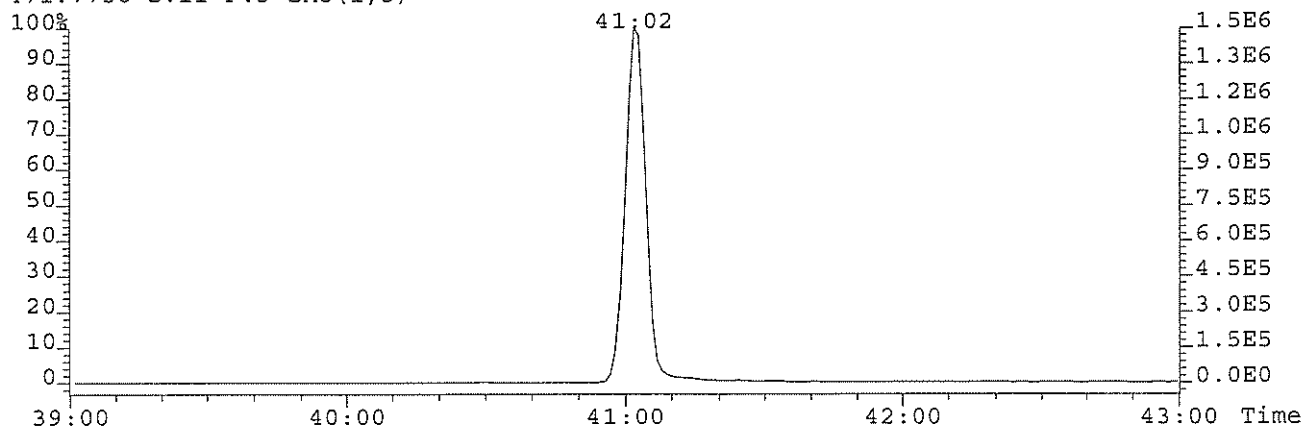
459.7348 S:11 F:3 SMO(1,3)



469.7780 S:11 F:3 SMO(1,3)

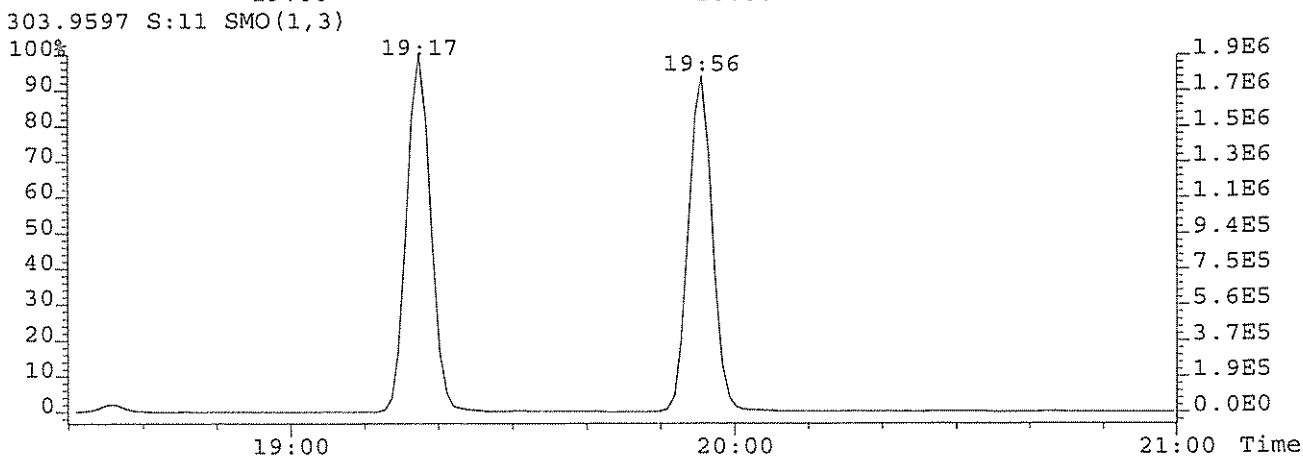
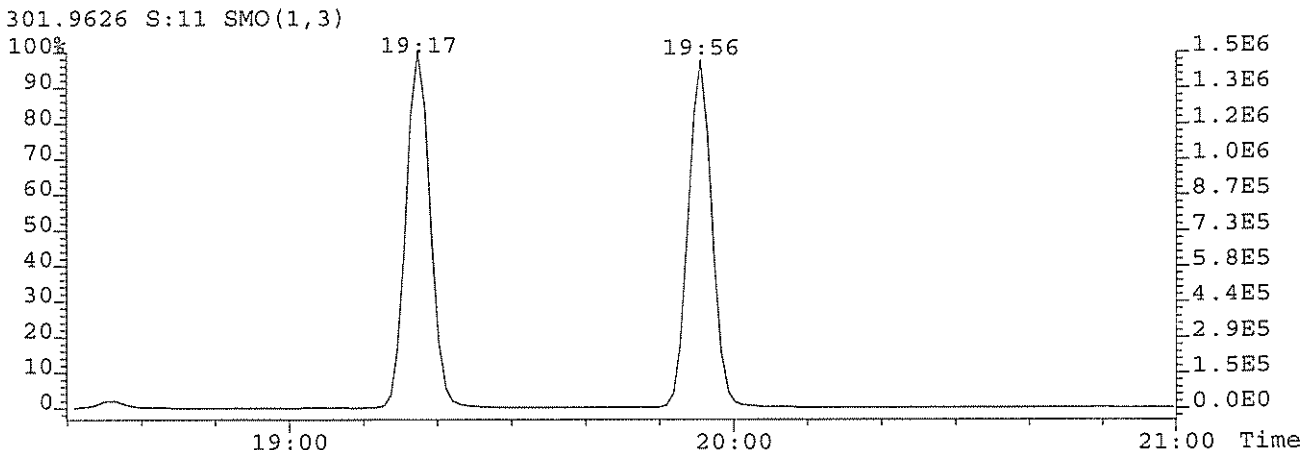
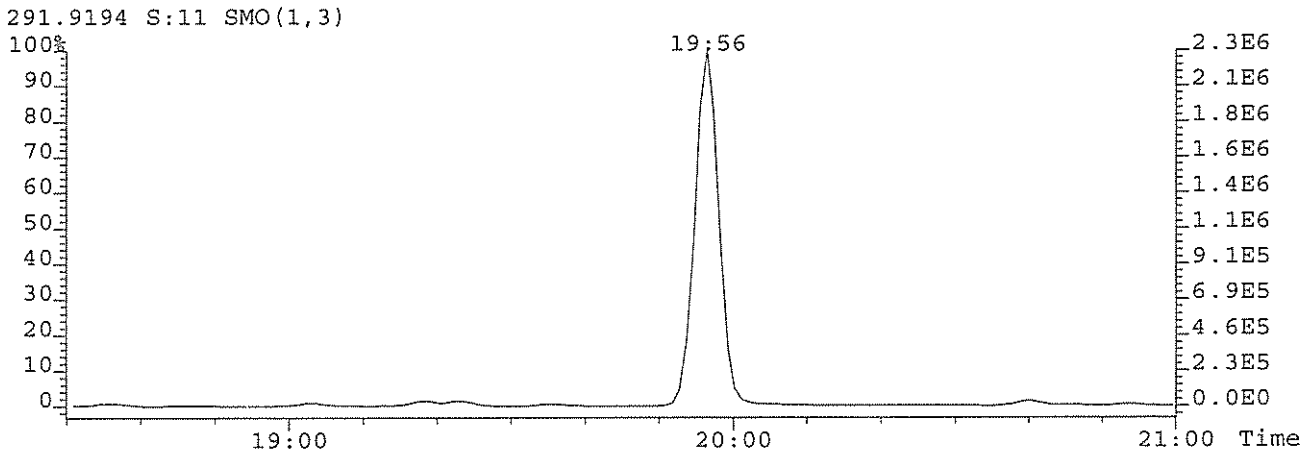
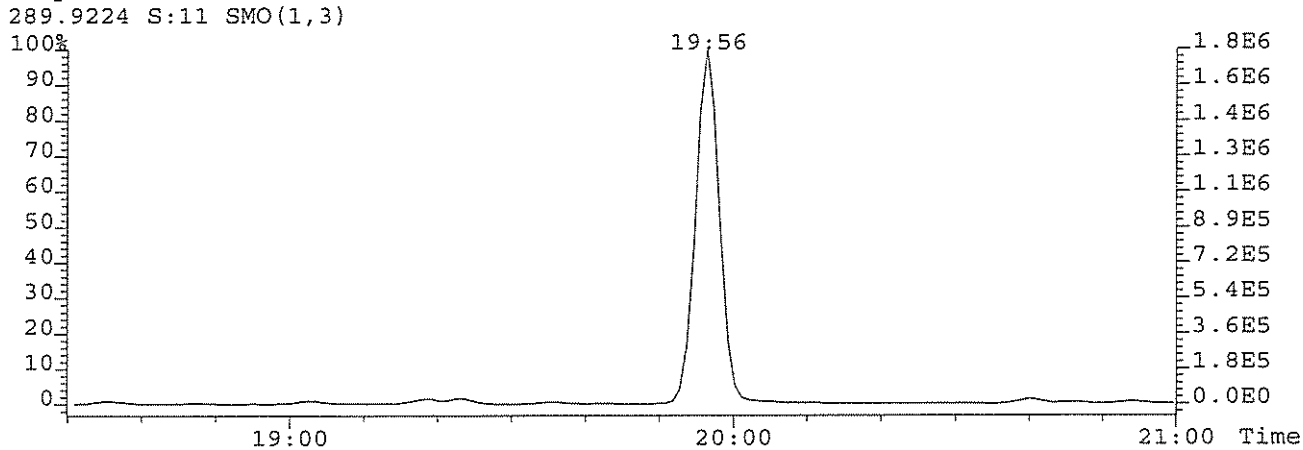


471.7750 S:11 F:3 SMO(1,3)



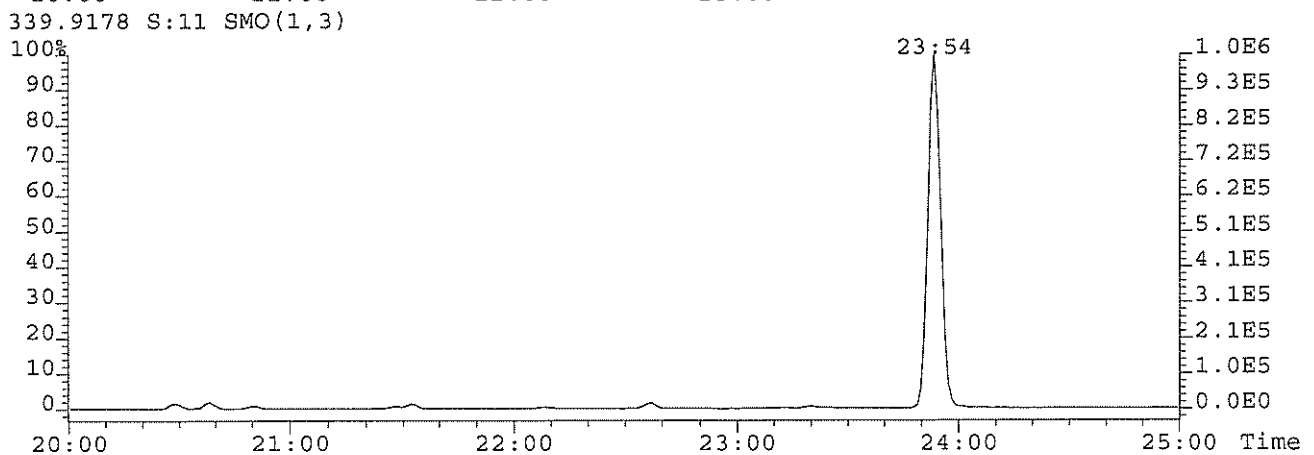
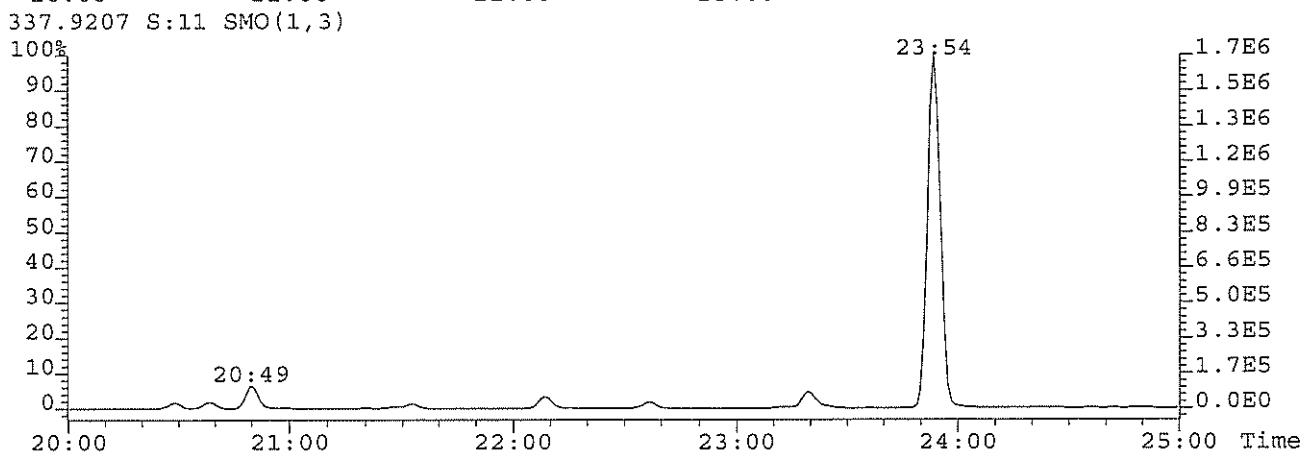
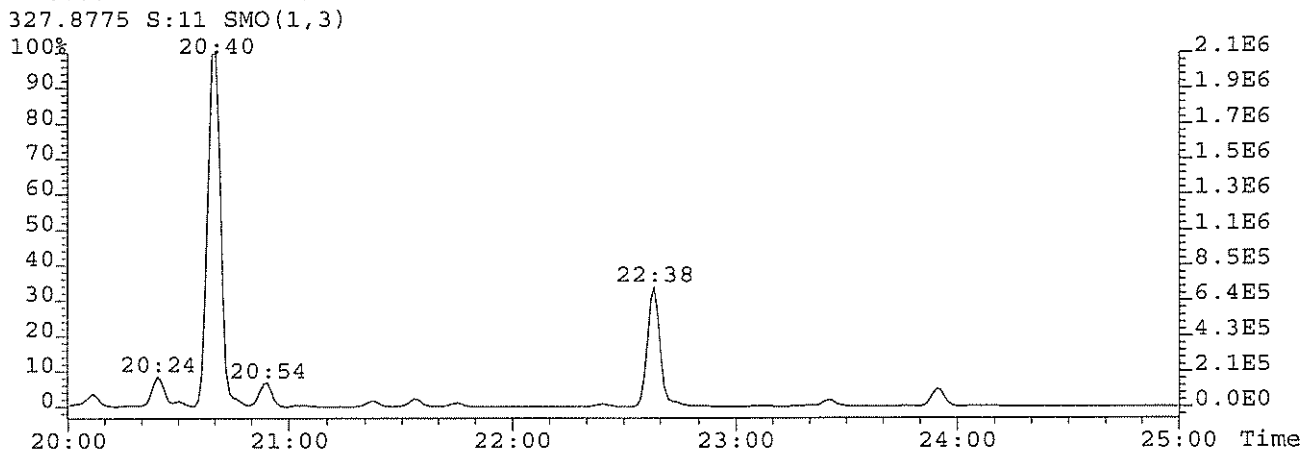
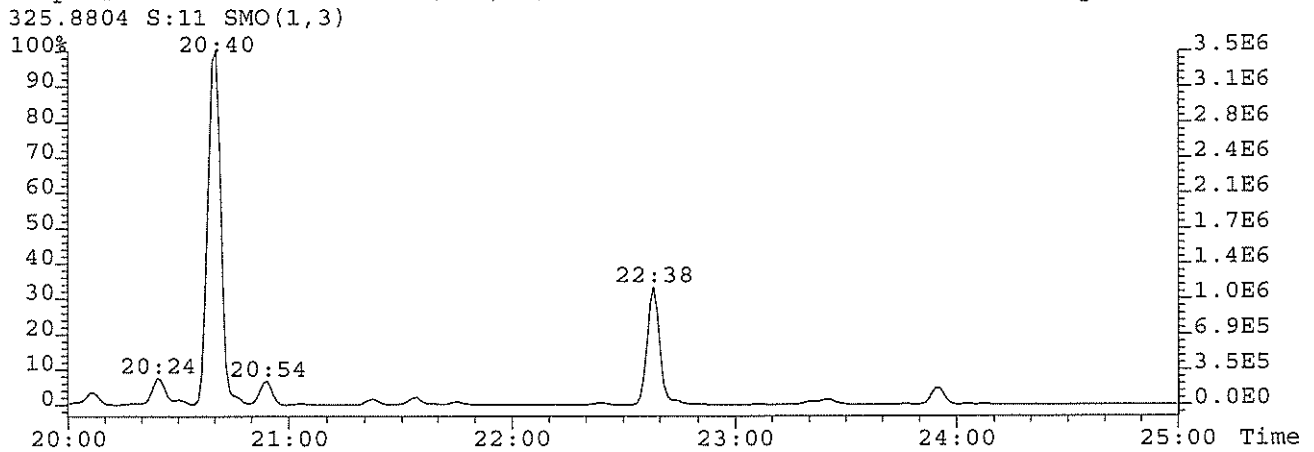
PCDDsクロマトグラム (12)  
(OCDD)

File:130711-2 #1-1430 Acq:12-JUL-2013 03:08:31 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(5-8,nP) Text:XE13 0949 3 Exp:RH-PD22



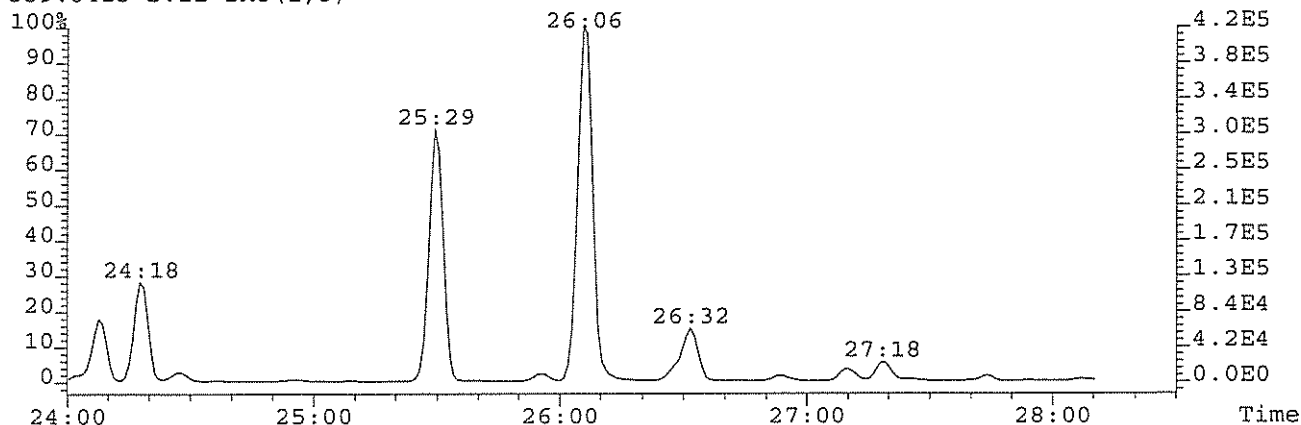
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 03:08:31 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(5-8,nP) Text:XE13 0949 3 Exp:RH-PD22

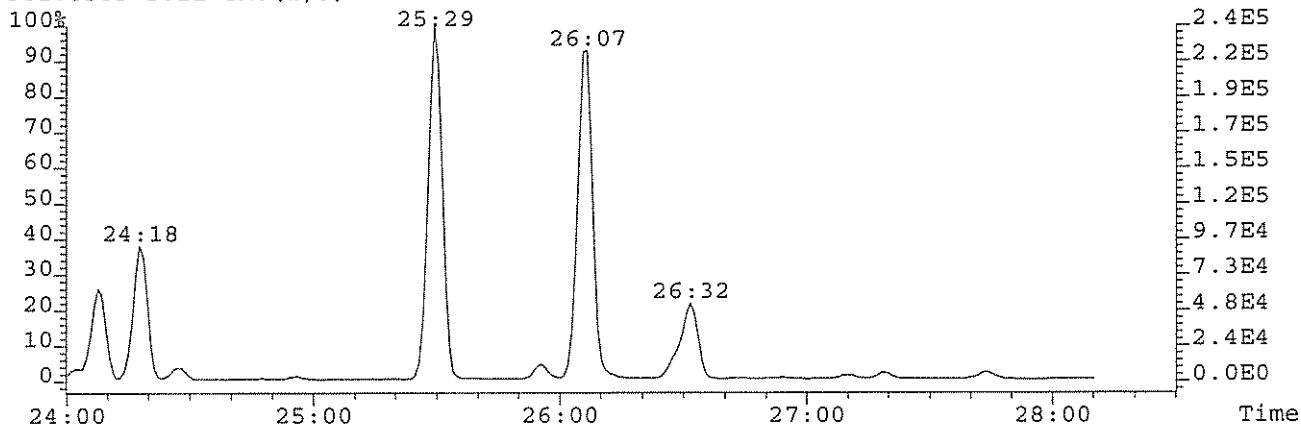


DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

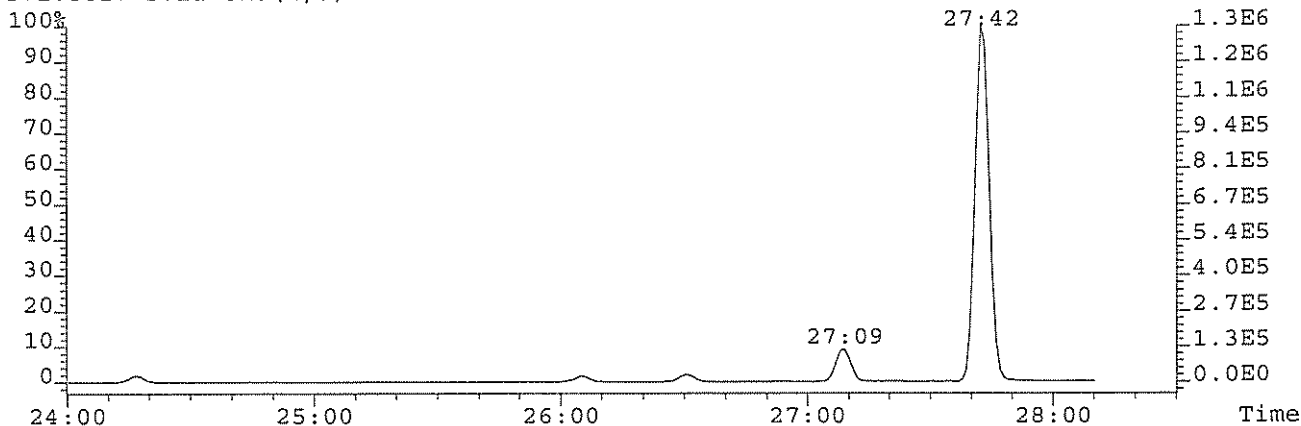
File:130711-2 #1-1430 Acq:12-JUL-2013 03:08:31 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(5-8,nP) Text:XE13 0949 3 Exp:RH-PD22  
359.8415 S:11 SMO(1,3)



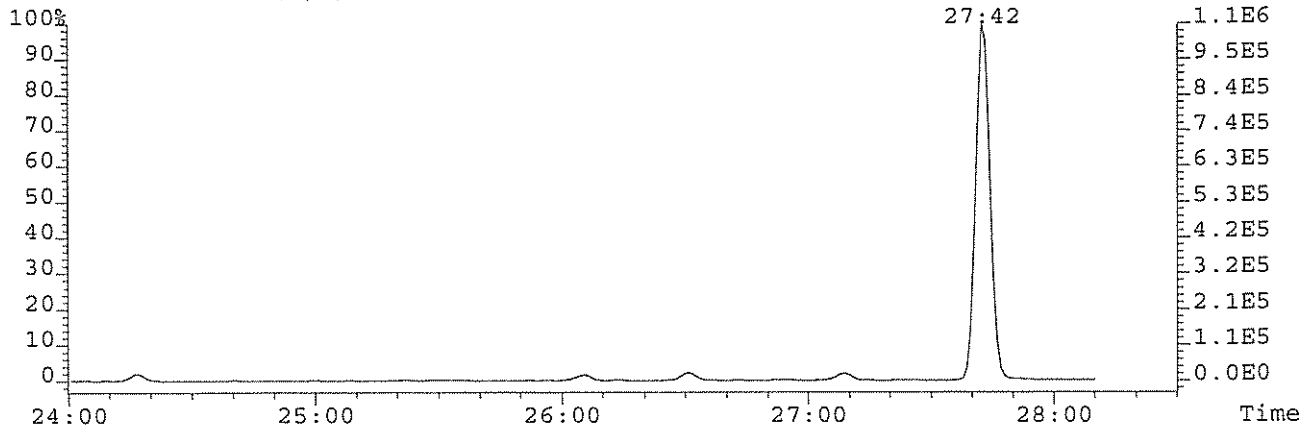
361.8385 S:11 SMO(1,3)



371.8817 S:11 SMO(1,3)



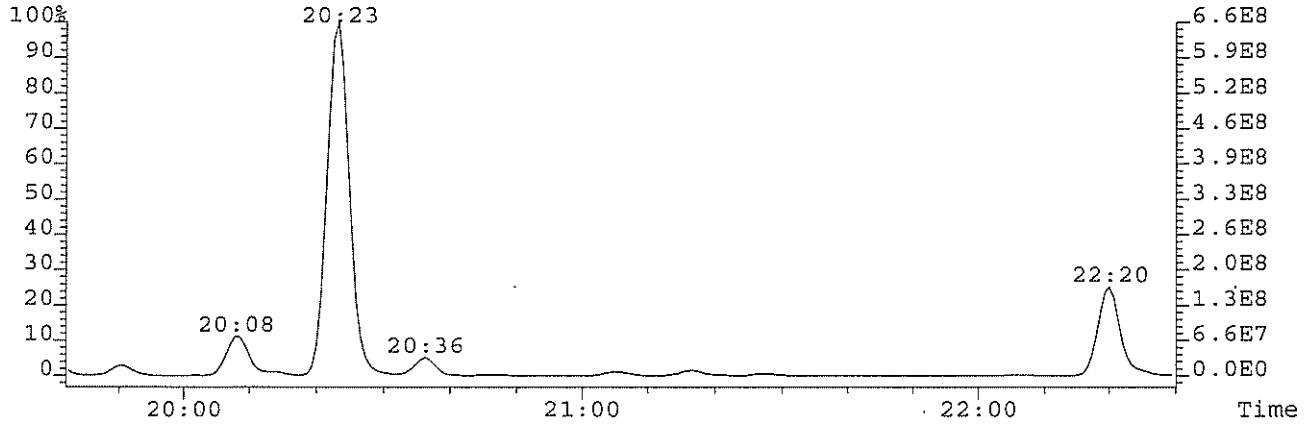
373.8788 S:11 SMO(1,3)



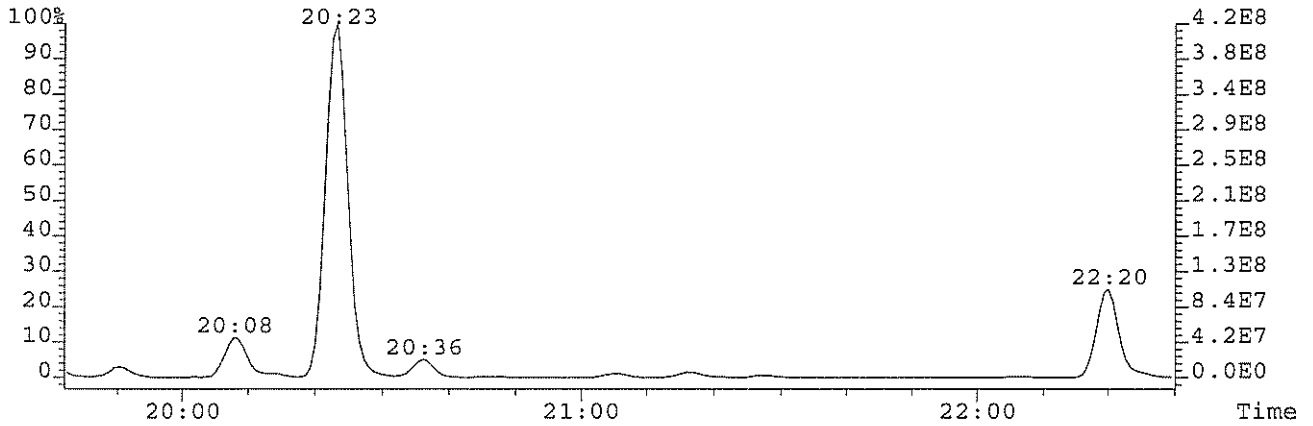
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130713 #1-2900 Acq:14-JUL-2013 02:44:51 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(mP) Text:XE13 0949 2 Exp:RH-MP11

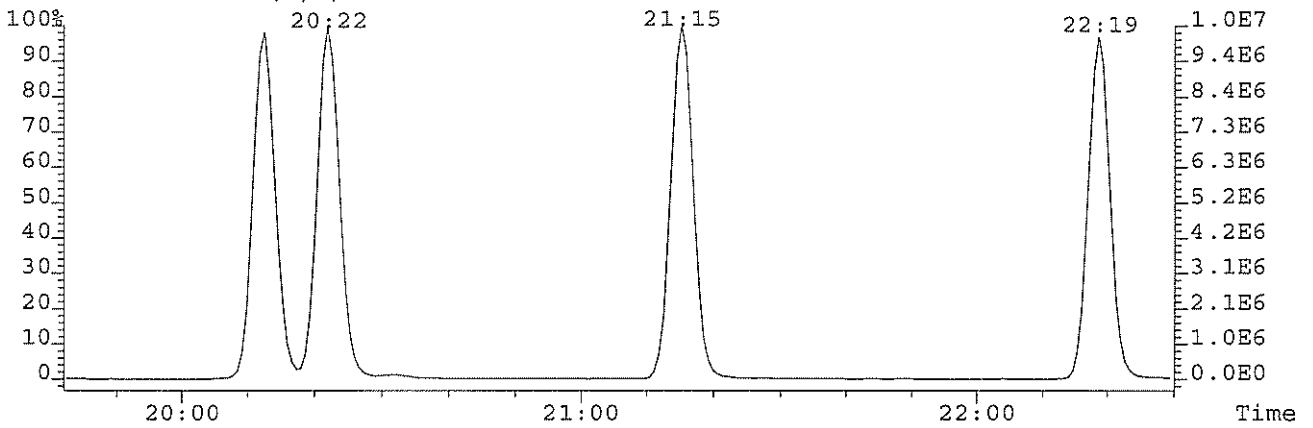
325.8804 S:22 SMO(1,3)



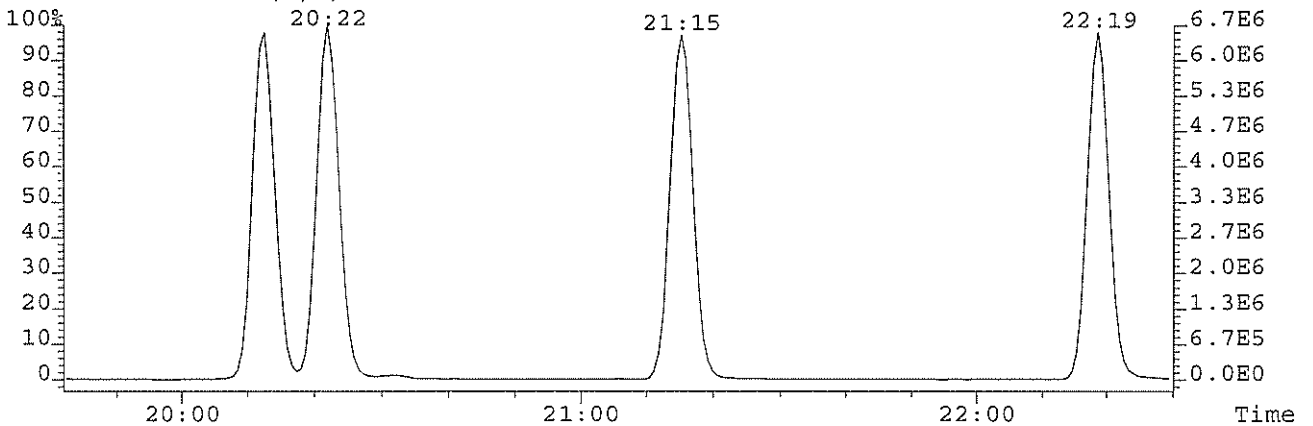
327.8775 S:22 SMO(1,3)



337.9207 S:22 SMO(1,3)

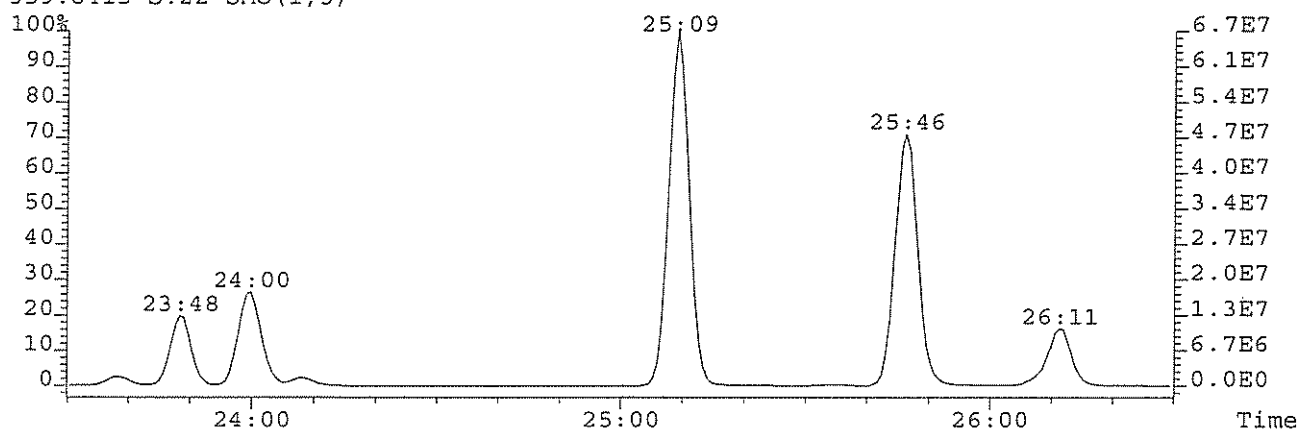


339.9178 S:22 SMO(1,3)

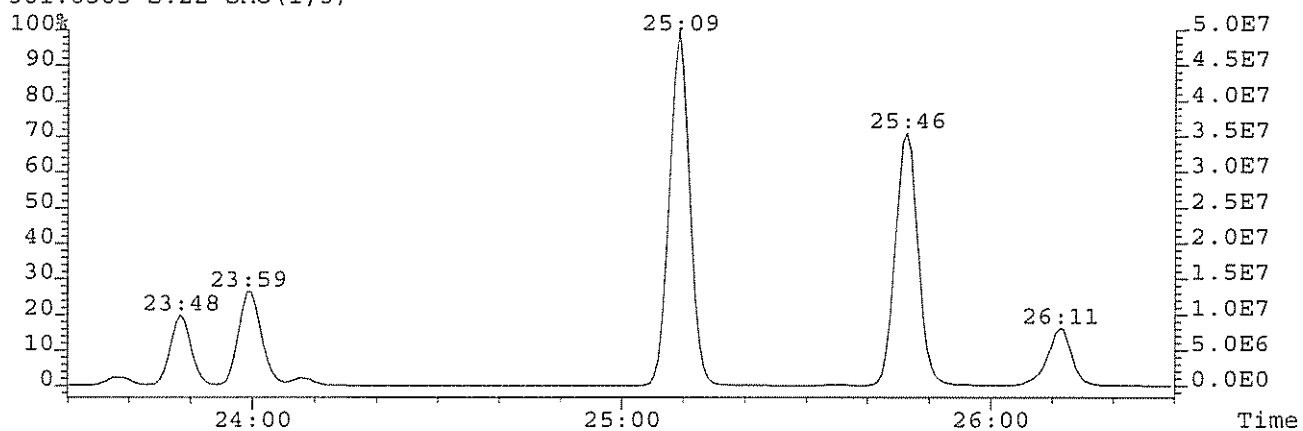


DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

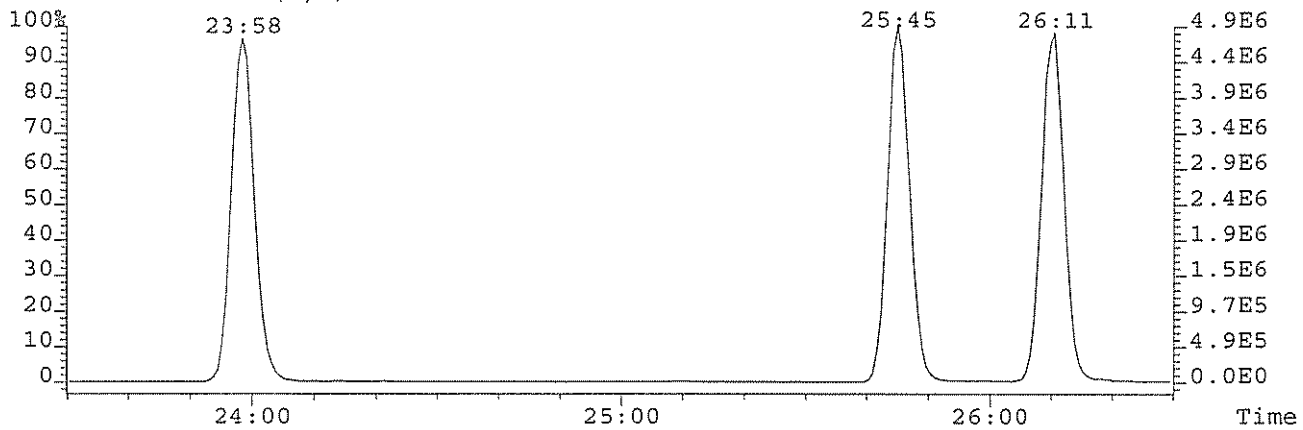
File:130713 #1-2900 Acq:14-JUL-2013 02:44:51 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(mP) Text:XE13 0949 2 Exp:RH-MP11  
359.8415 S:22 SMO(1,3)



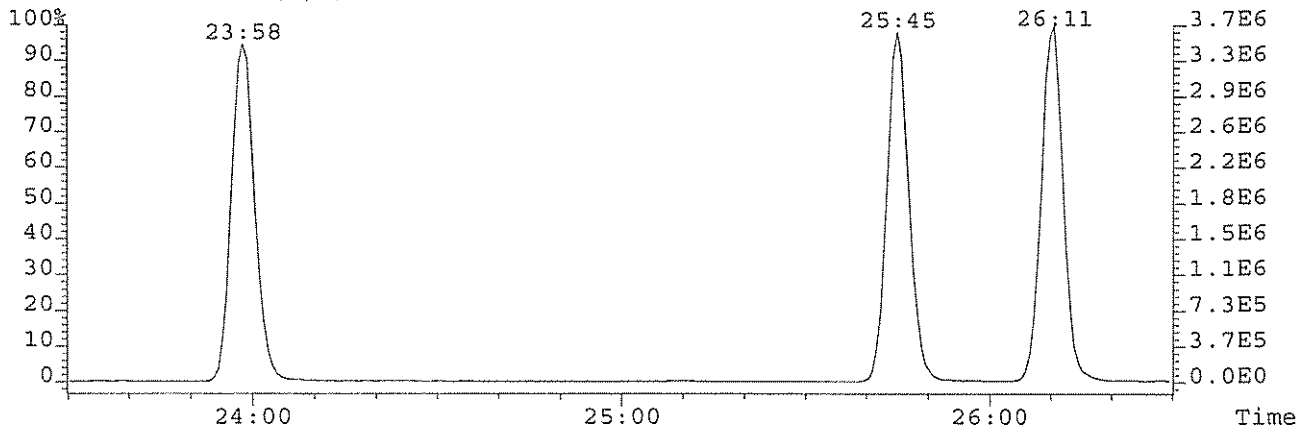
361.8385 S:22 SMO(1,3)



371.8817 S:22 SMO(1,3)

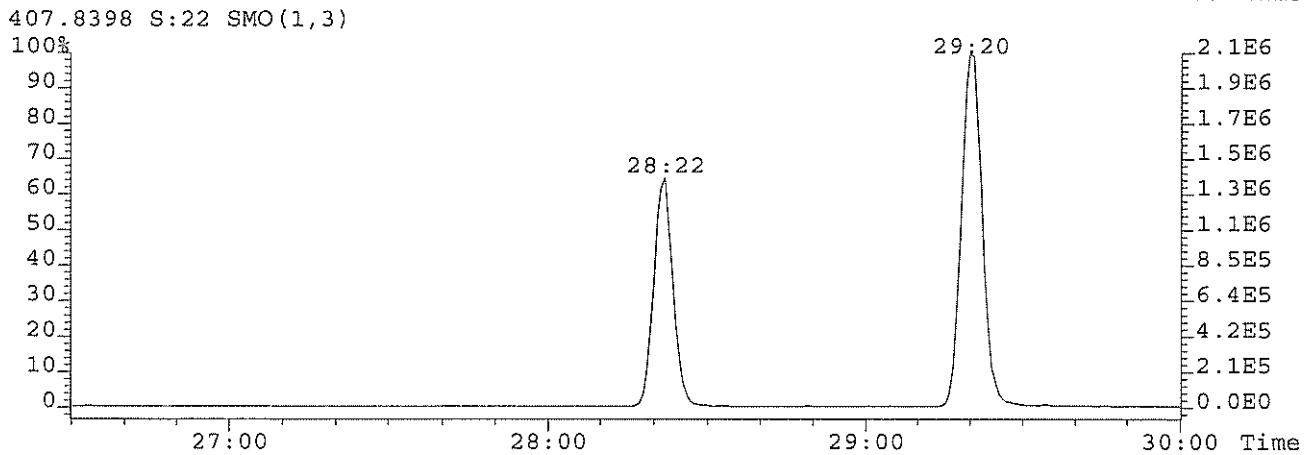
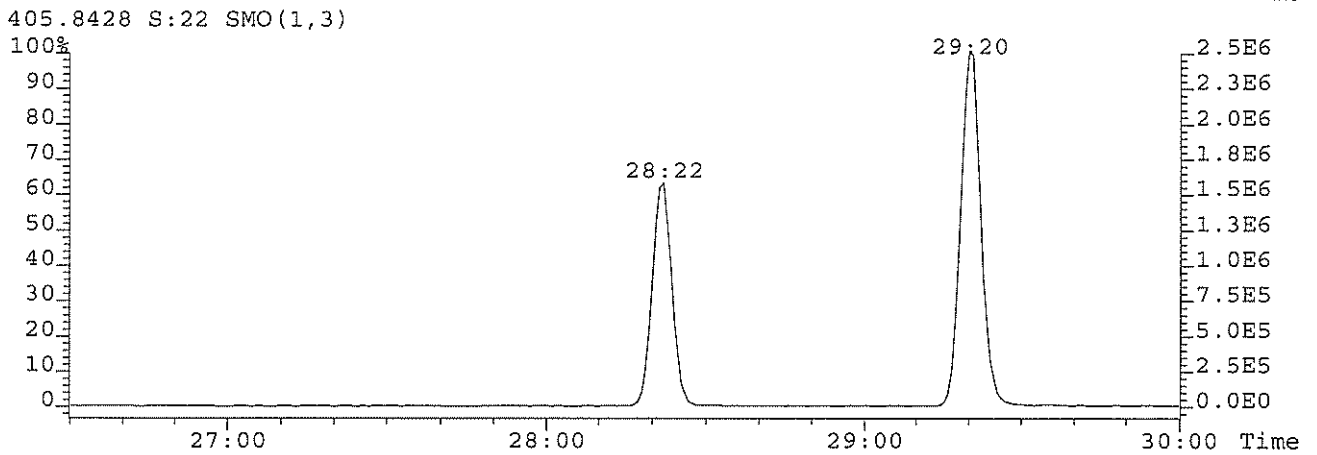
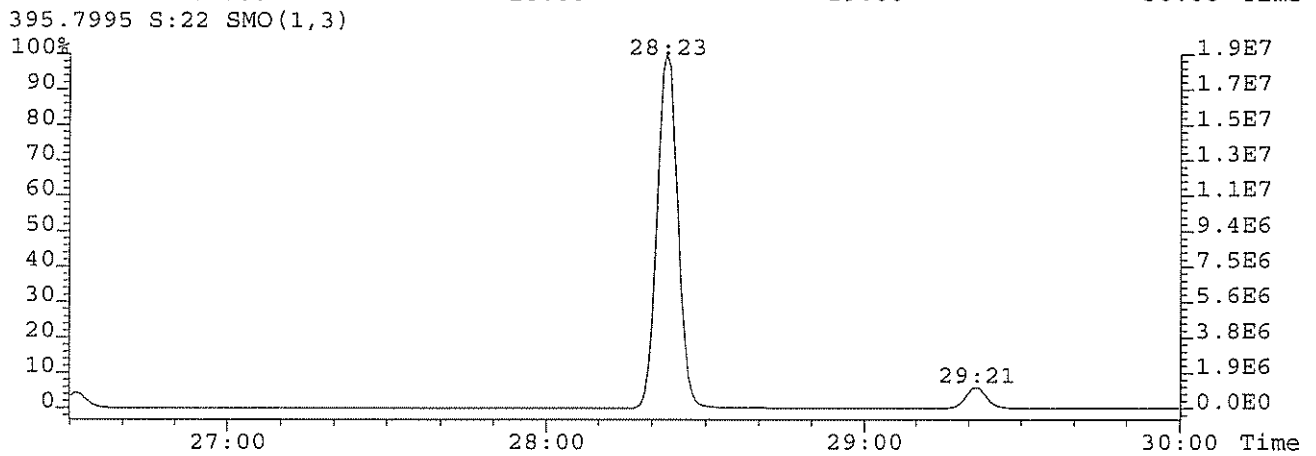
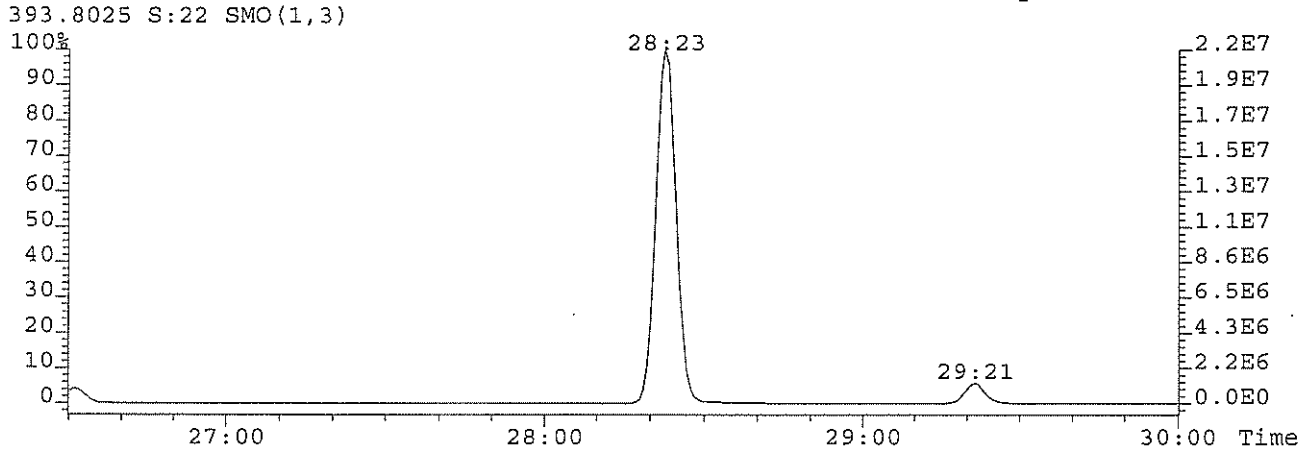


373.8788 S:22 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130713 #1-2900 Acq:14-JUL-2013 02:44:51 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(mP) Text:XE13 0949 2 Exp:RH-MP11

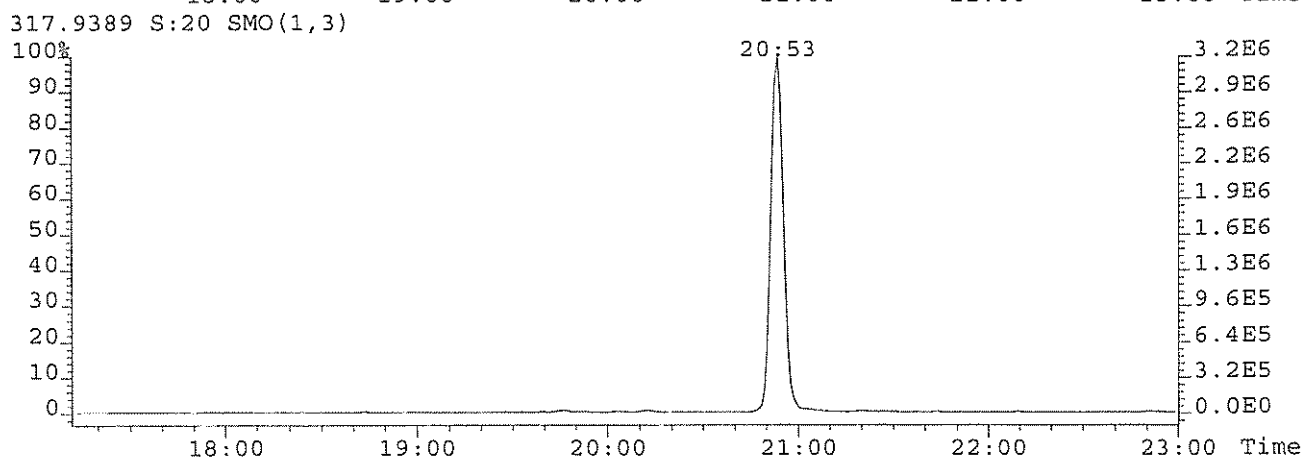
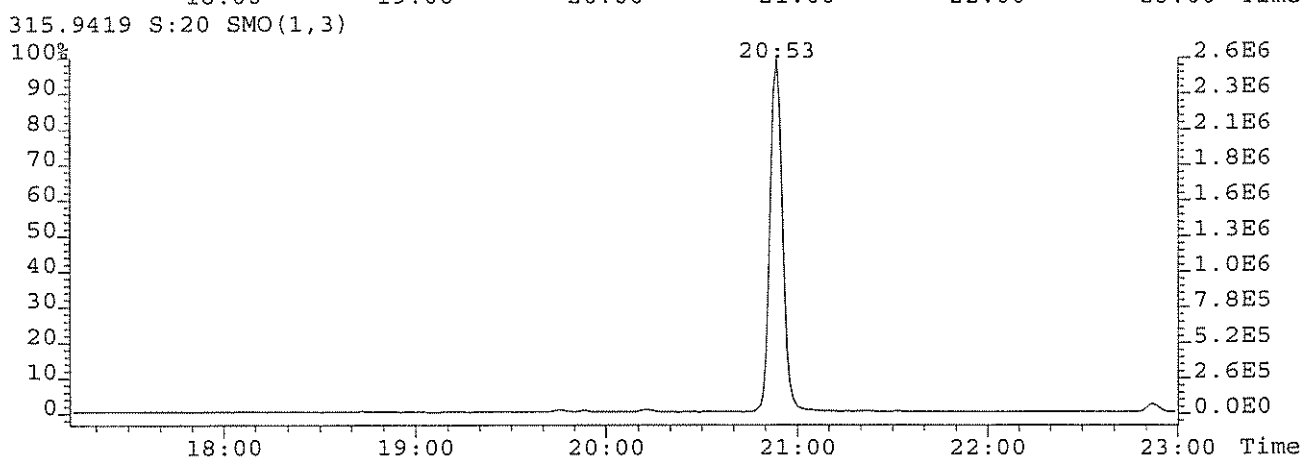
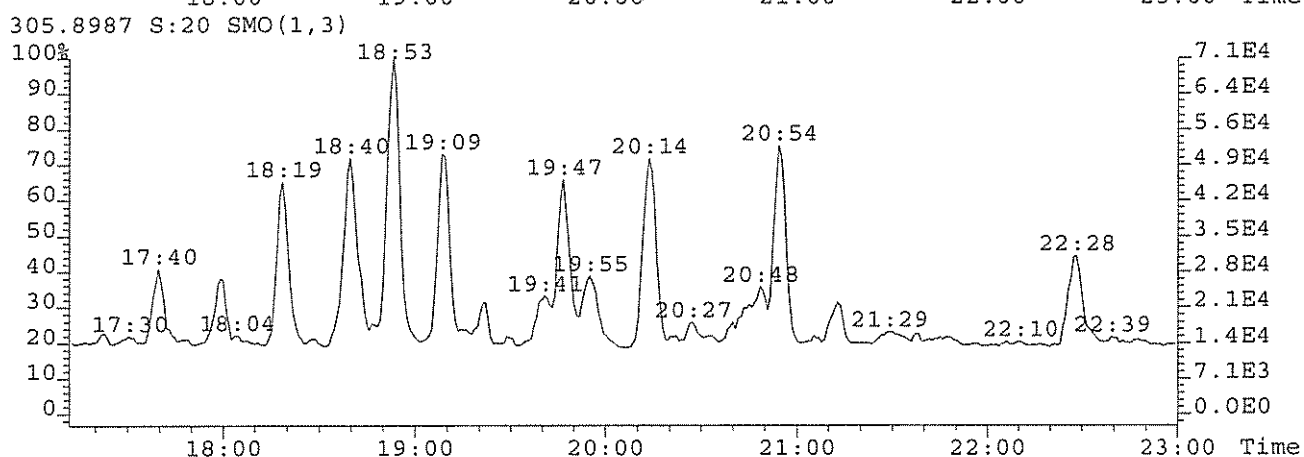
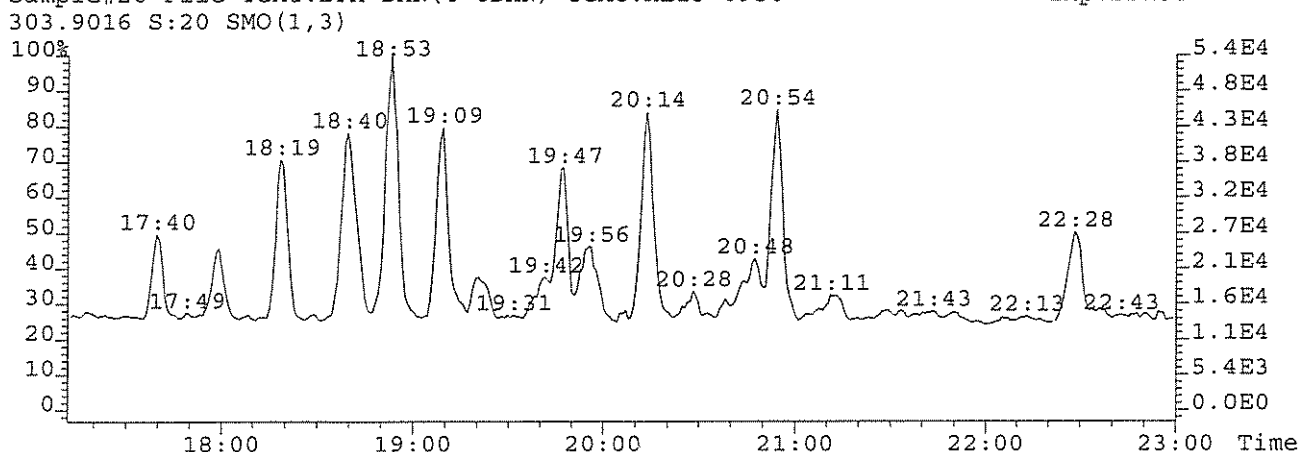


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

試料管理番号	XE 130950
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.4



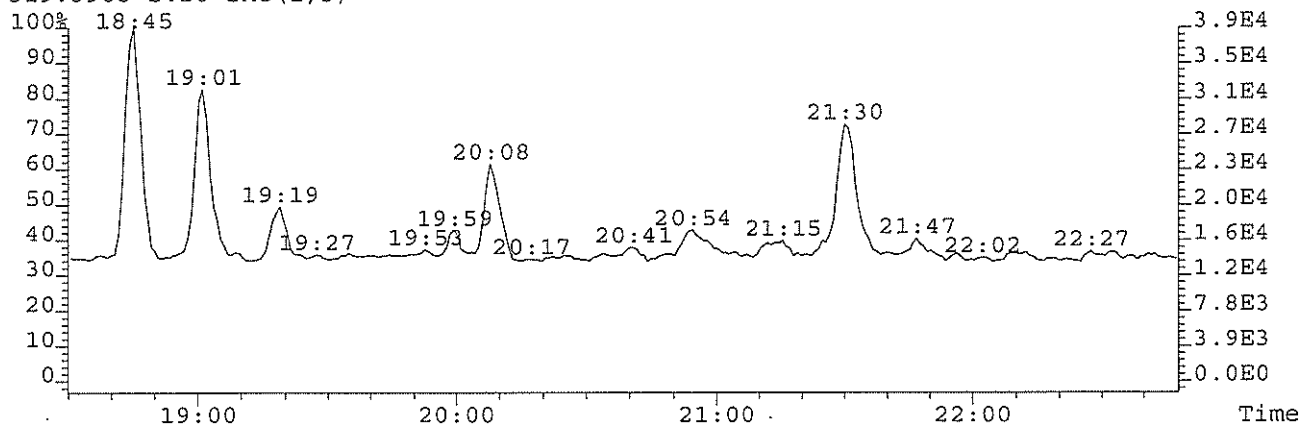
File:130710-2 #1-1577 Acq:11-JUL-2013 06:32:25 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:BPX-DXN(4-6DXN) Text:XE13 0950 Exp:BPX04



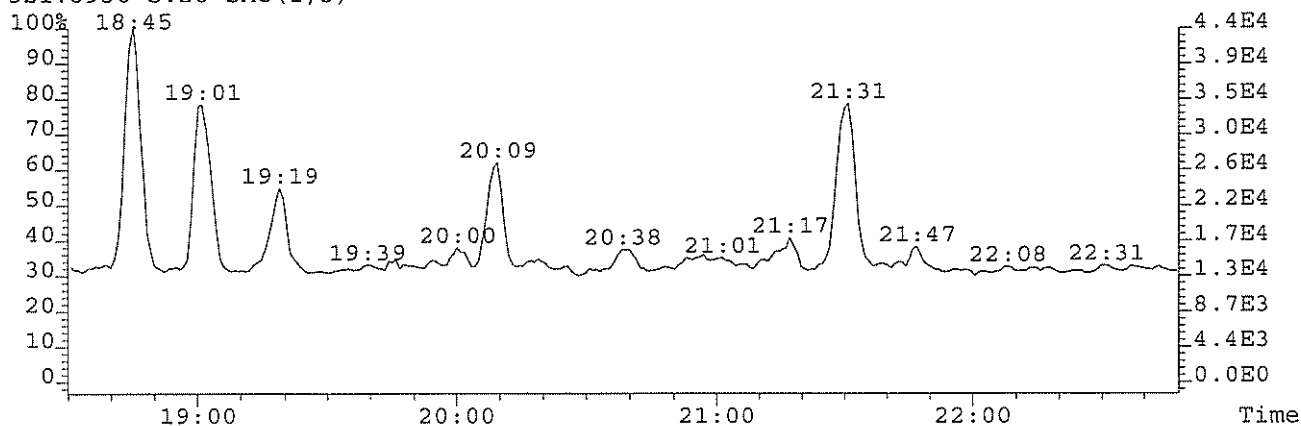
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130710-2 #1-1577 Acq:11-JUL-2013 06:32:25 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:BPX-DXN(4-6DXN) Text:XE13 0950 Exp:BPX04

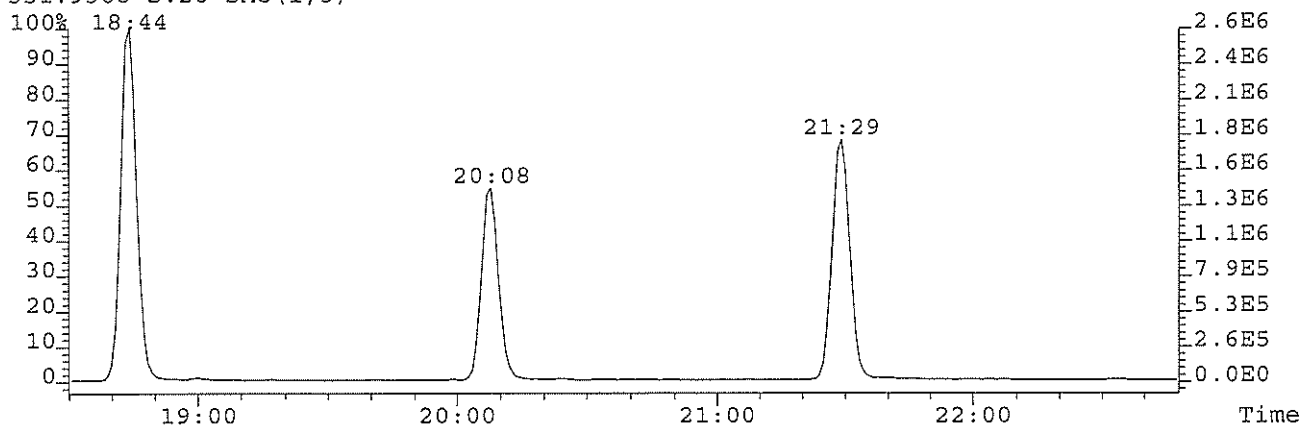
319.8965 S:20 SMO(1,3)



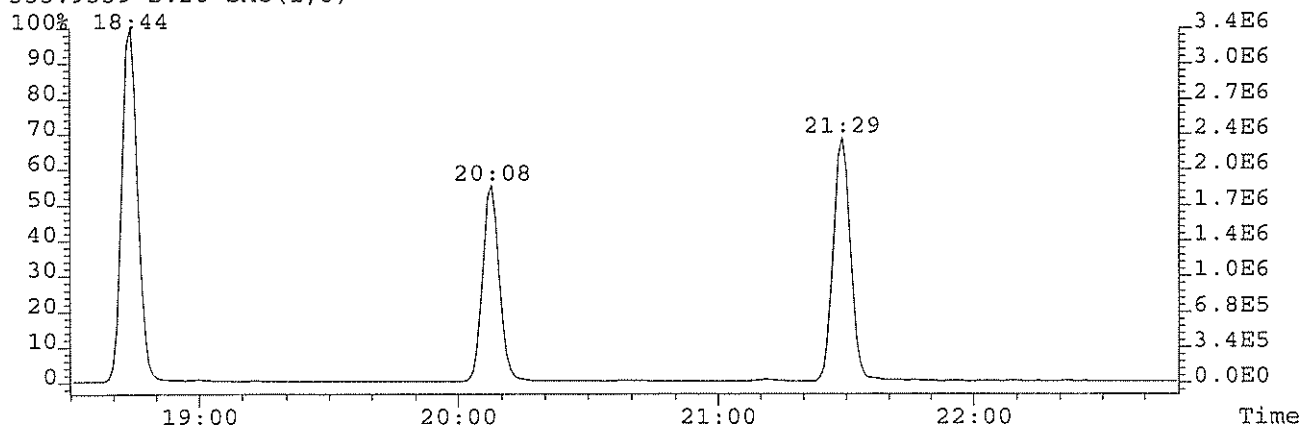
321.8936 S:20 SMO(1,3)



331.9368 S:20 SMO(1,3)



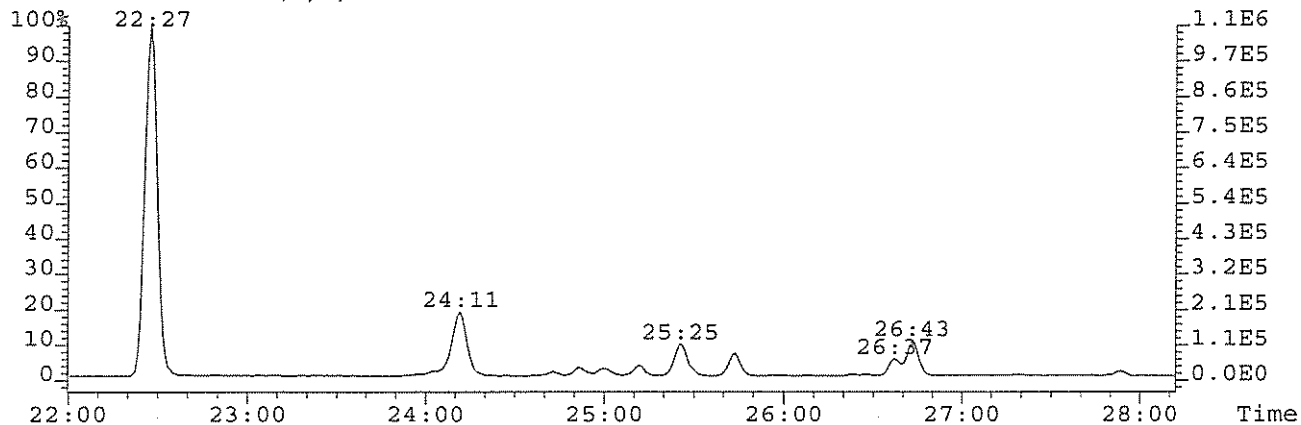
333.9339 S:20 SMO(1,3)



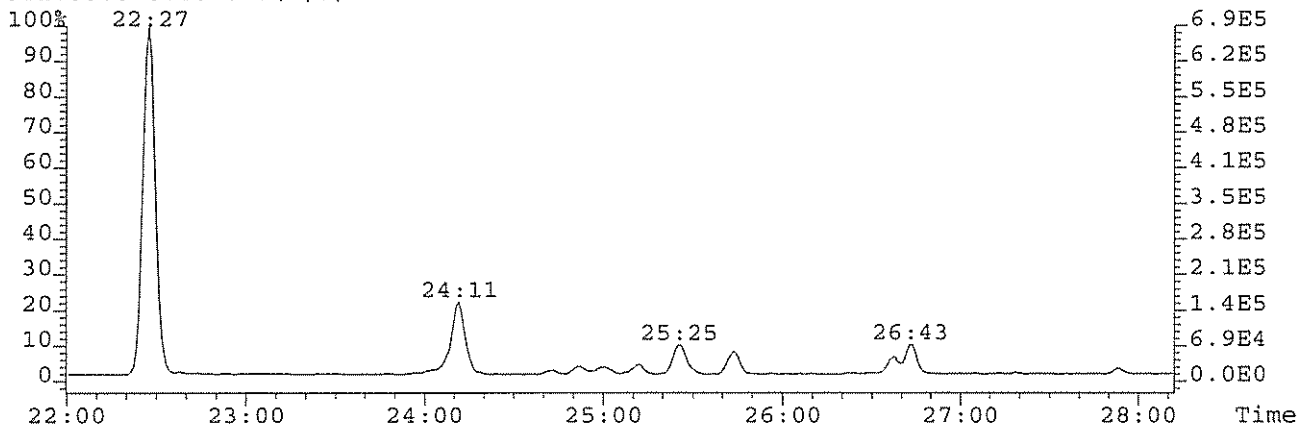
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130710-2 #1-1577 Acq:11-JUL-2013 06:32:25 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:BPX-DXN(4-6DXN) Text:XE13 0950 Exp:BPX04

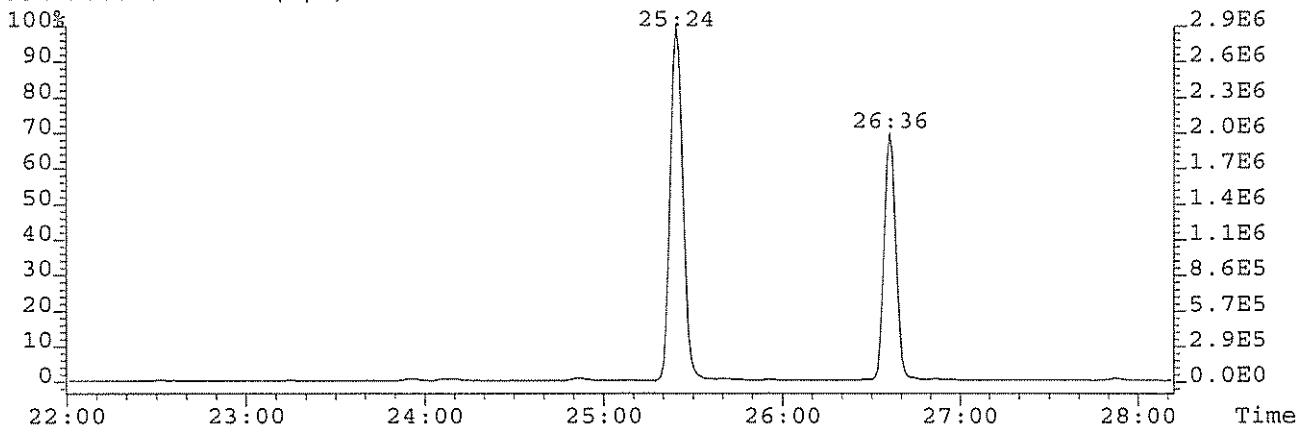
339.8597 S:20 SMO(1,3)



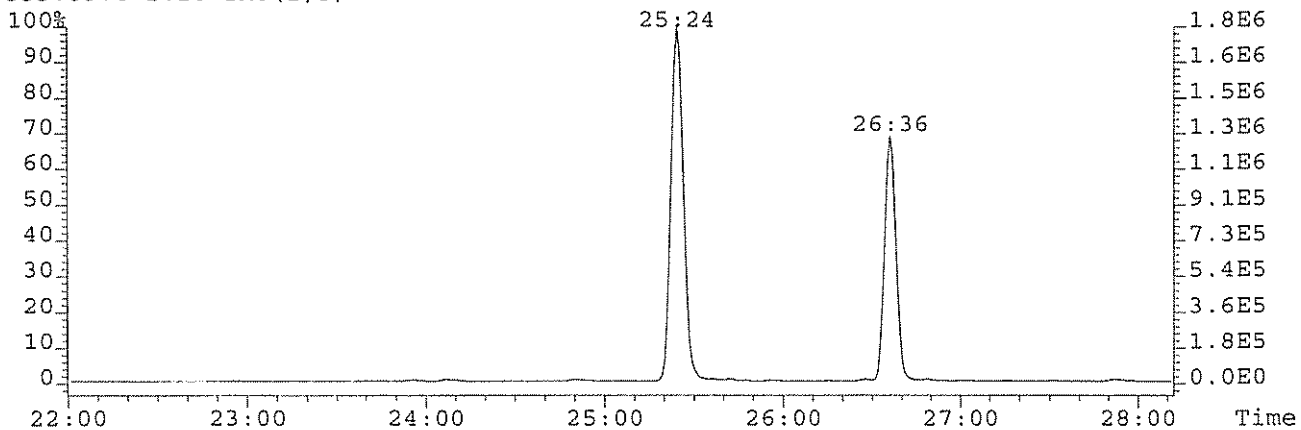
341.8568 S:20 SMO(1,3)



351.9000 S:20 SMO(1,3)

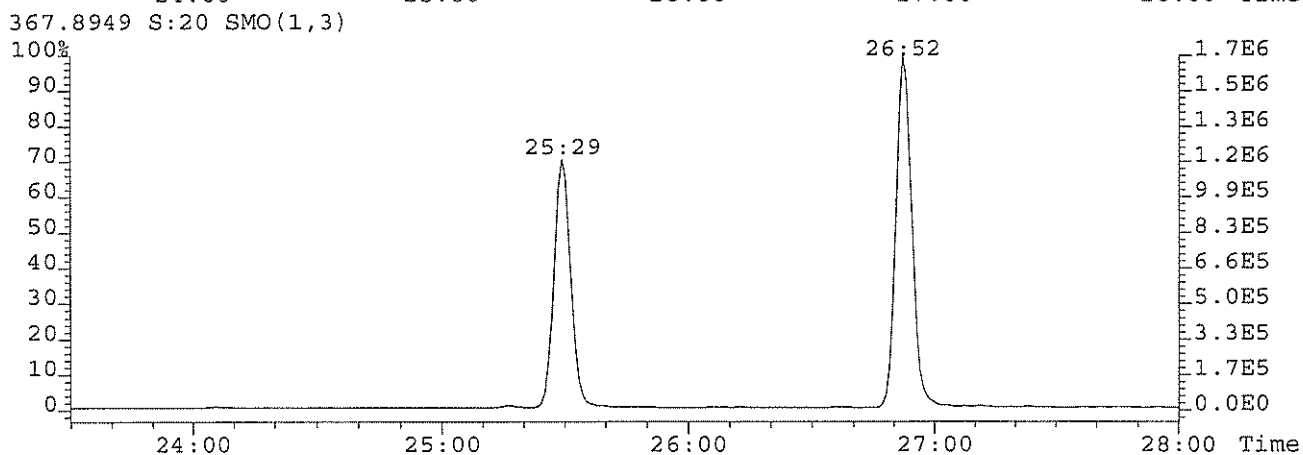
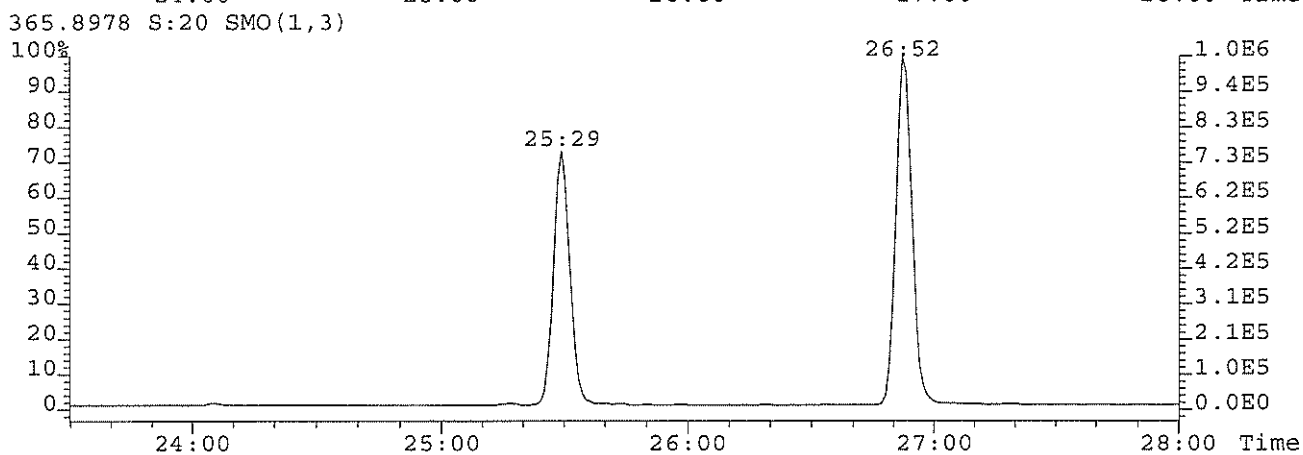
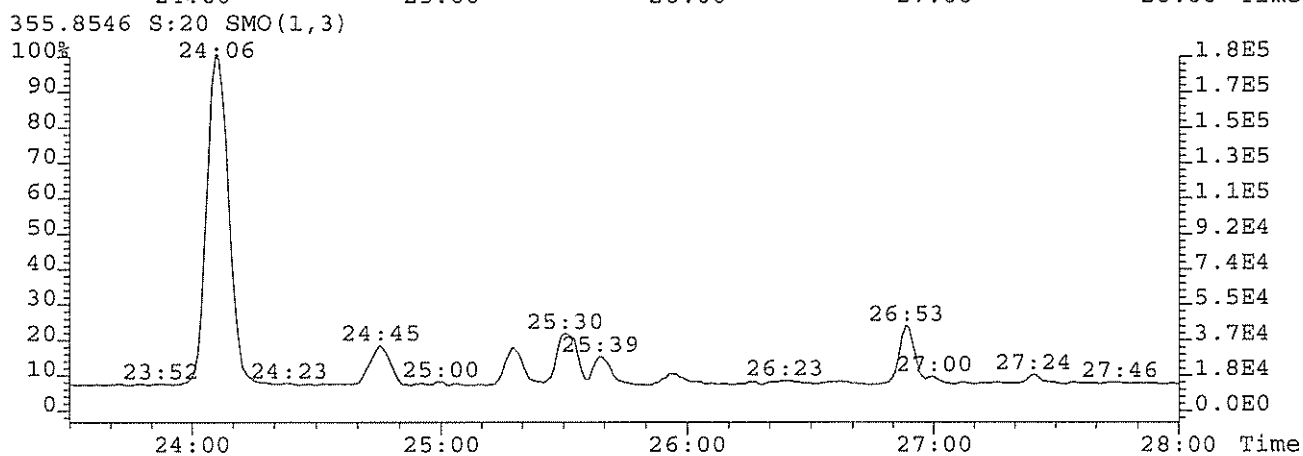
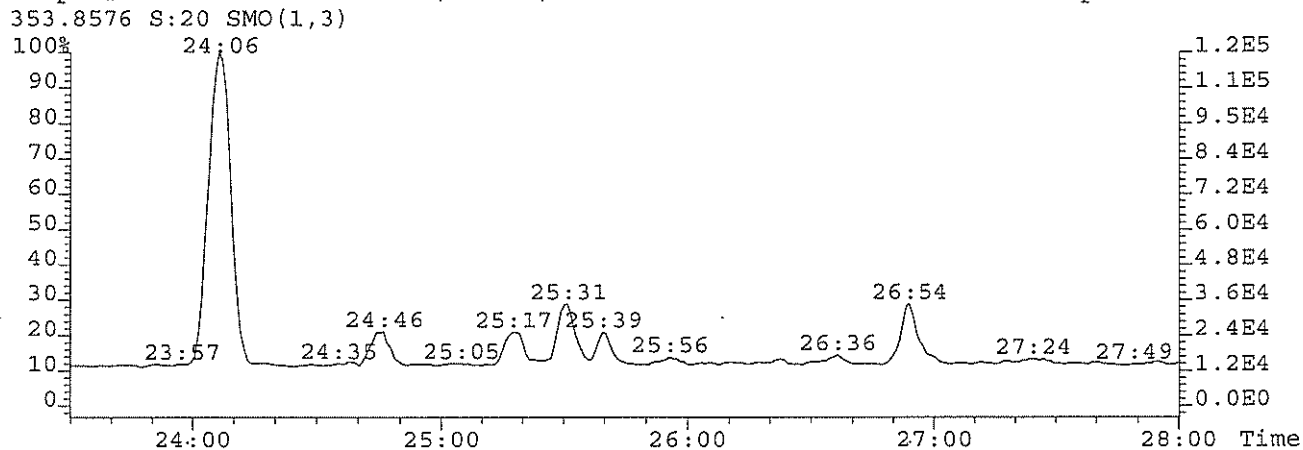


353.8970 S:20 SMO(1,3)



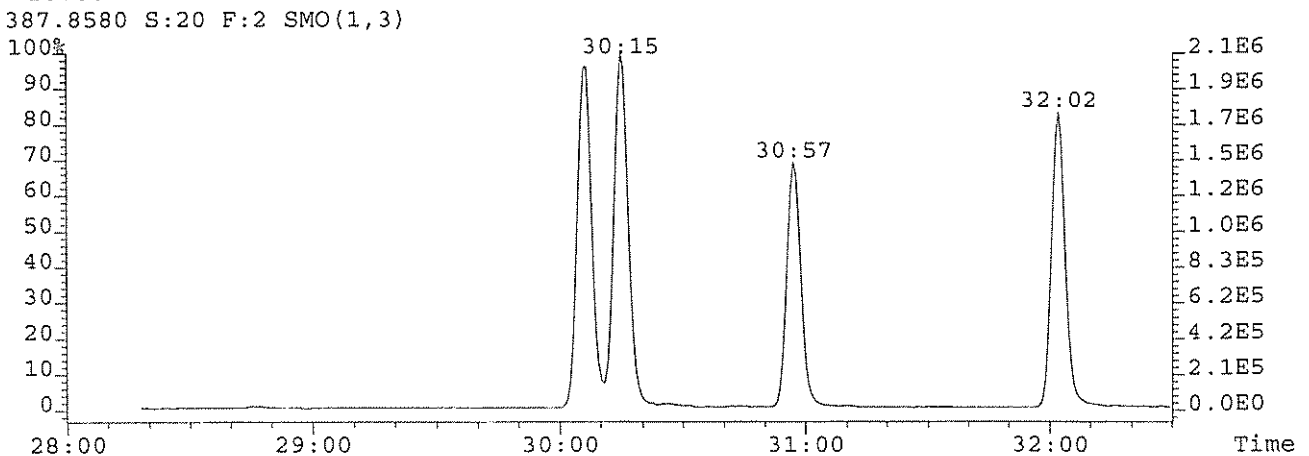
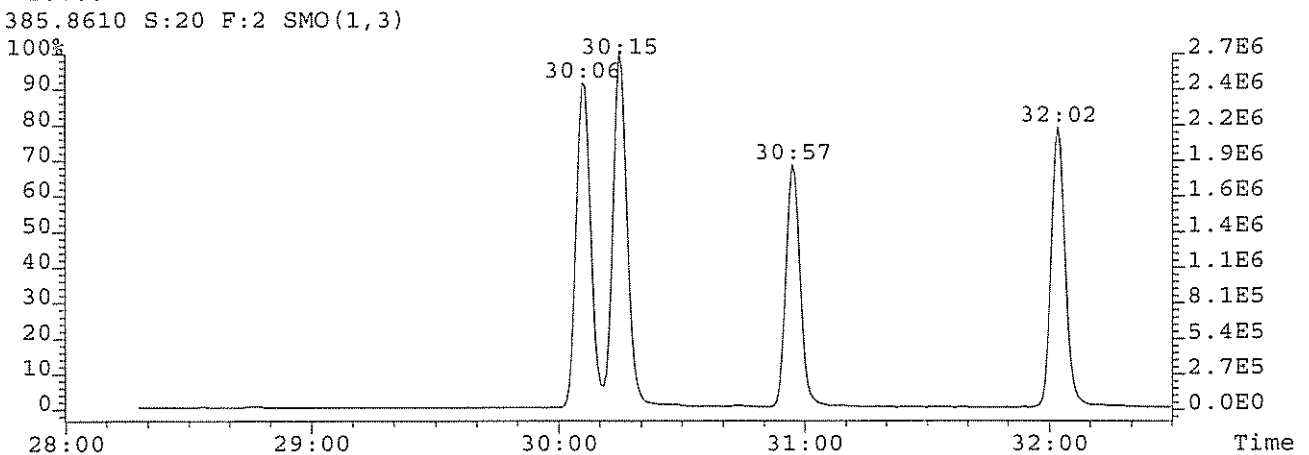
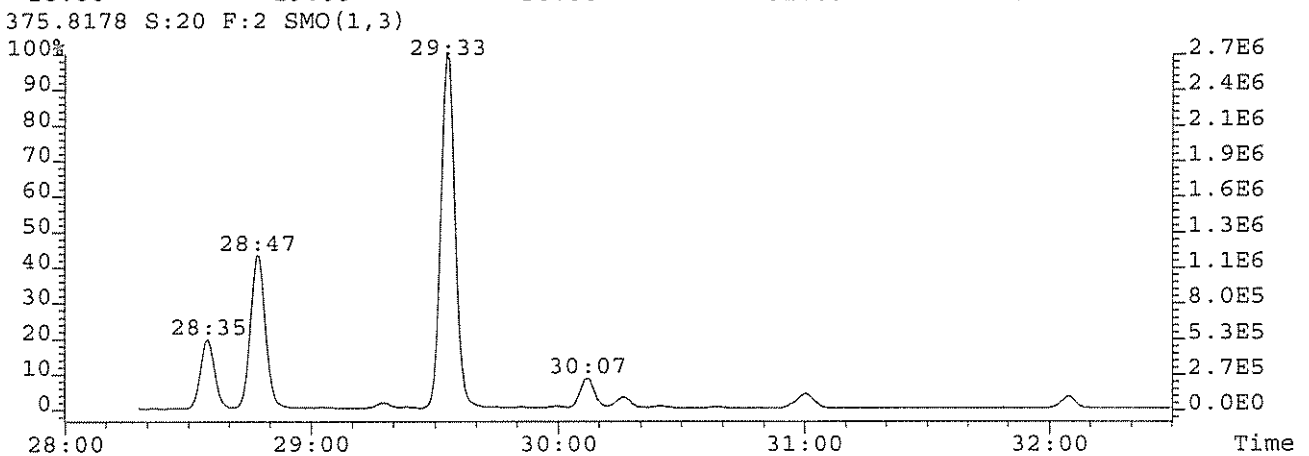
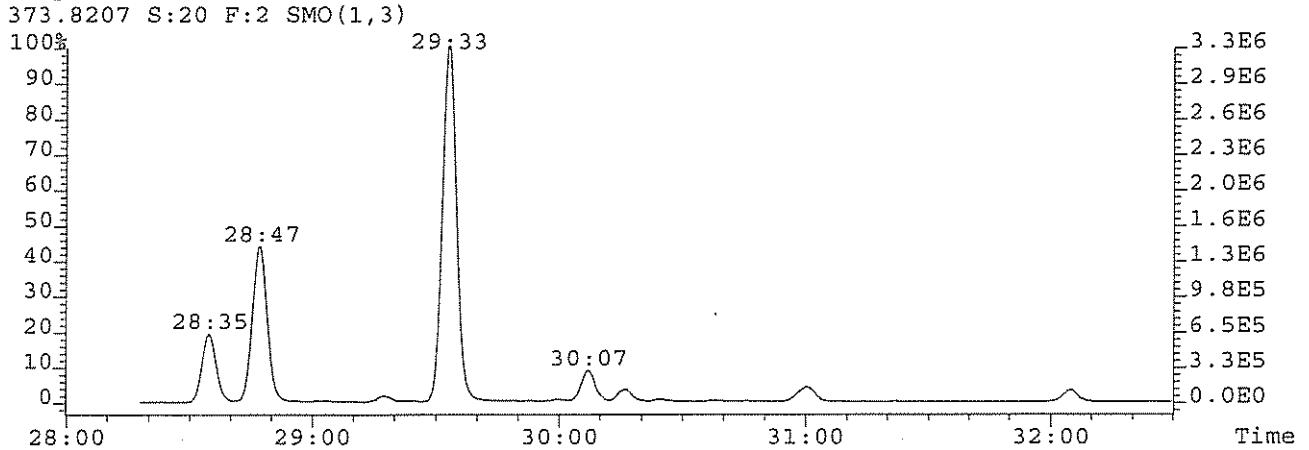
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130710-2 #1-1577 Acq:11-JUL-2013 06:32:25 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:BPX-DXN(4-6DXN) Text:XE13 0950 Exp:BPX04



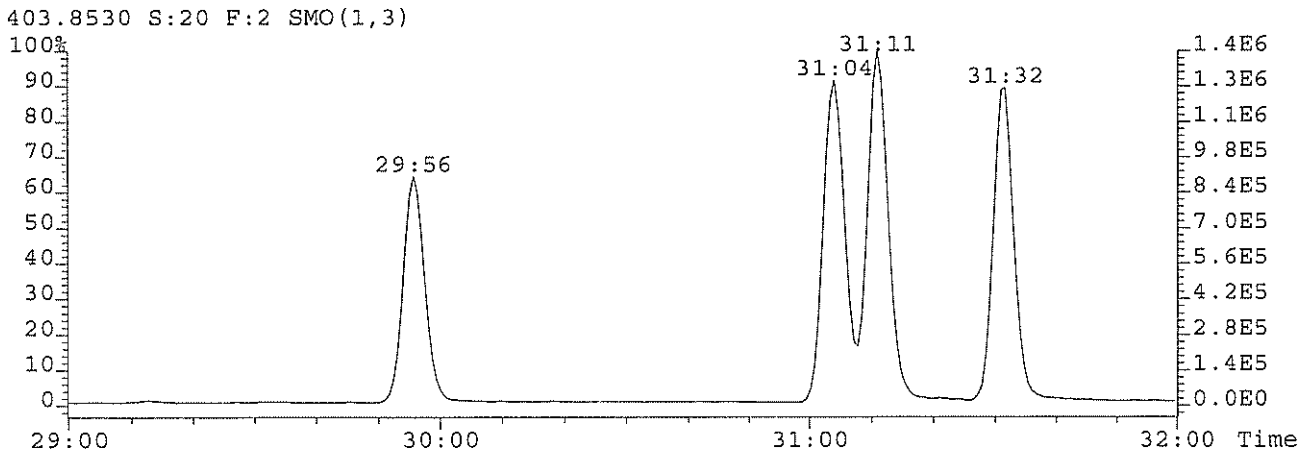
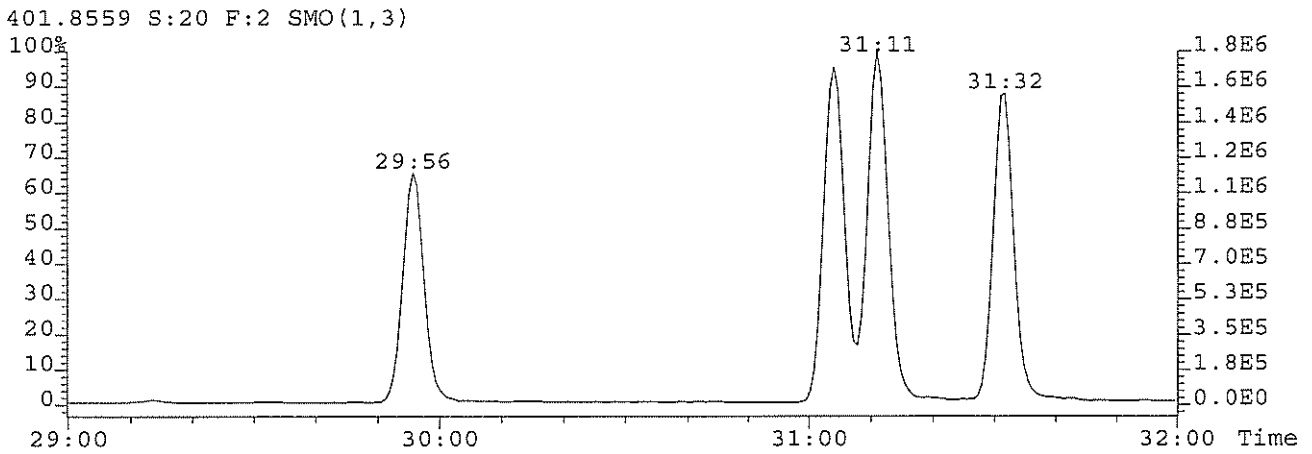
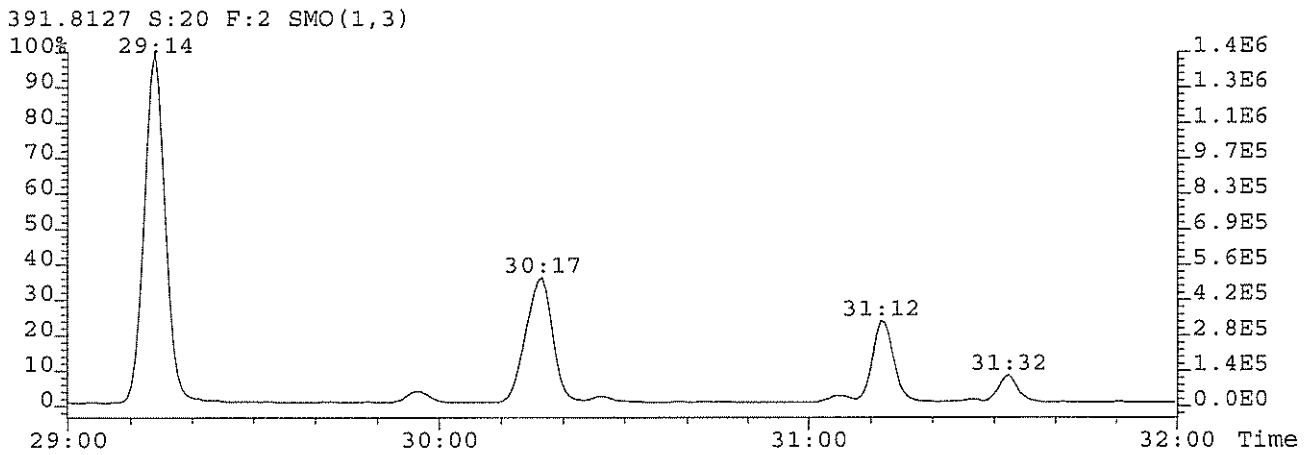
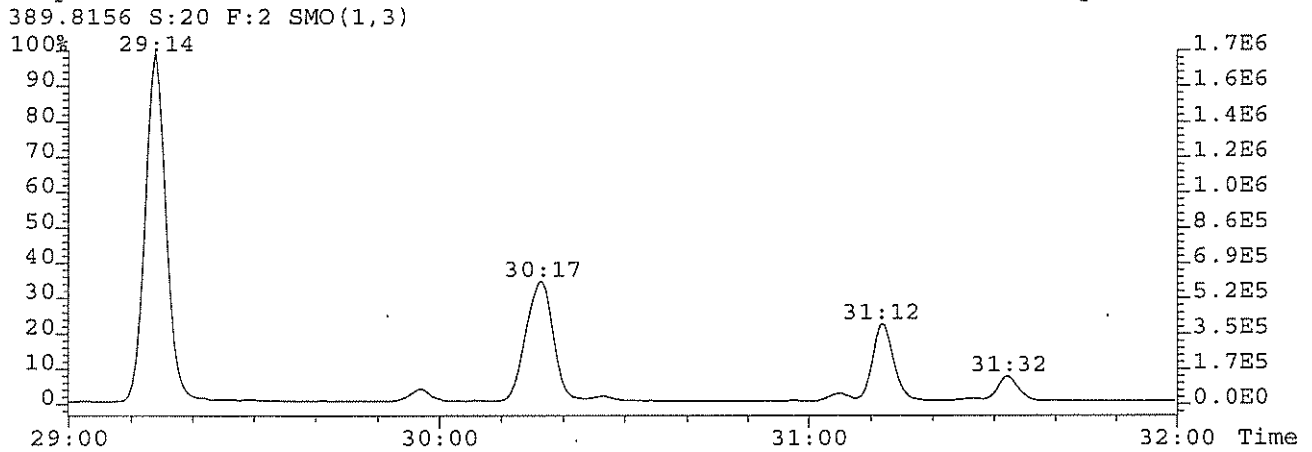
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130710-2 #1-1117 Acq:11-JUL-2013 06:32:25 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:BPX-DXN(4-6DXN) Text:XE13 0950 Exp:BPX04



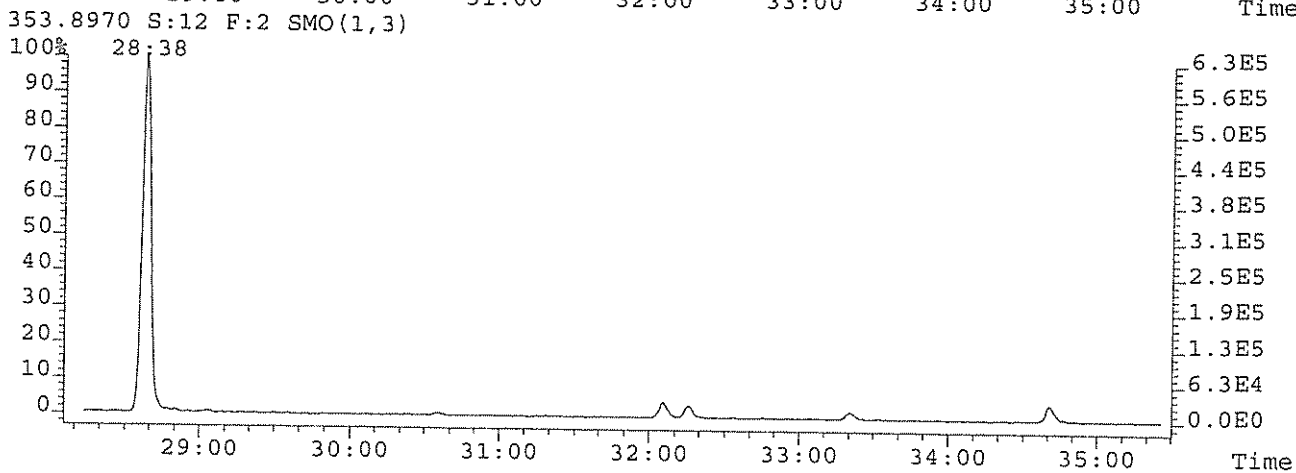
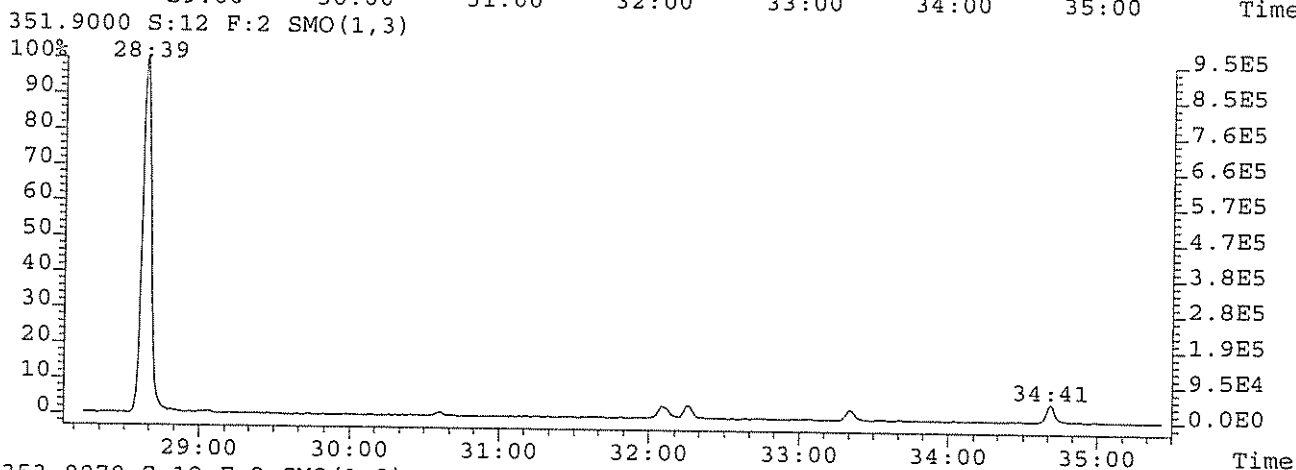
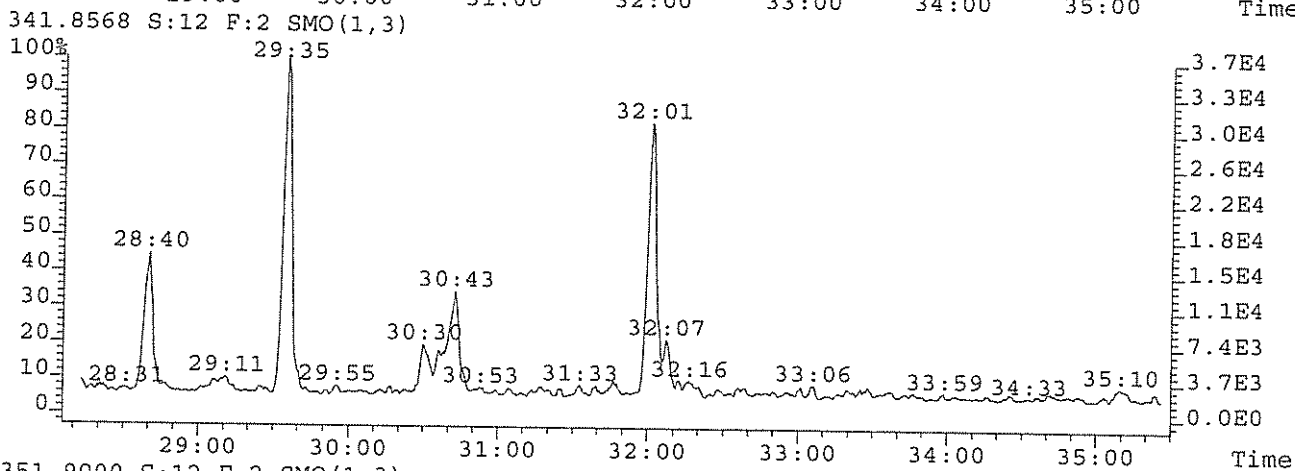
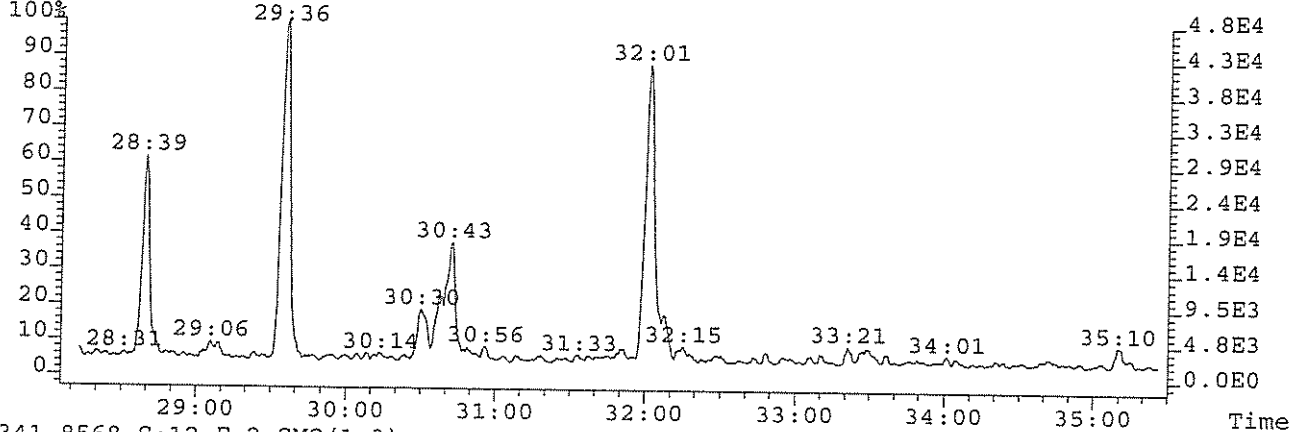
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130710-2 #1-1117 Acq:11-JUL-2013 06:32:25 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:BPX-DXN(4-6DXN) Text:XE13 0950 Exp:BPX04



PCDDsクロマトグラム (6)  
(HxCDDs)

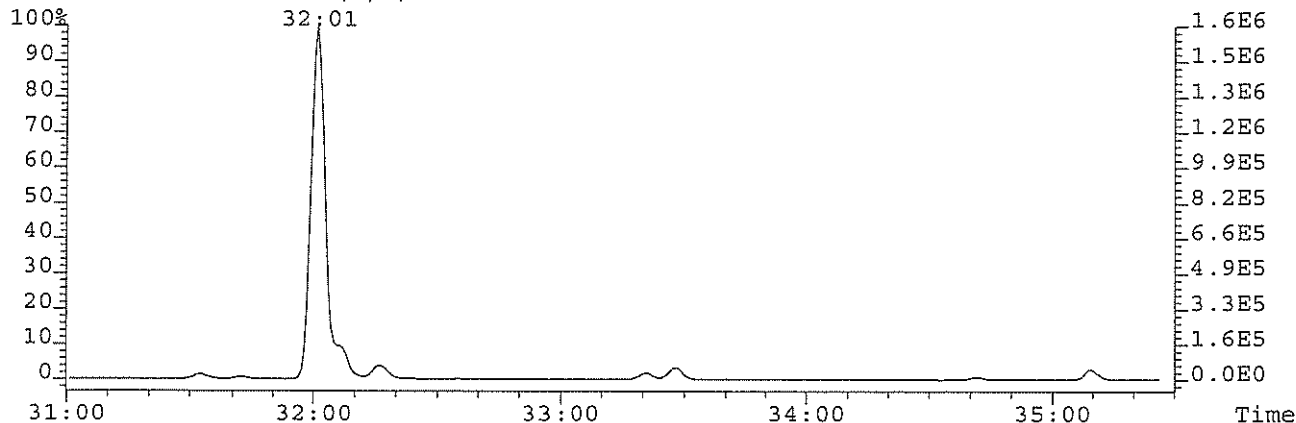
File:130711-2 #1-648 Acq:12-JUL-2013 03:57:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#12 File Text:RH-12ms(5-8,nP) Text:XE13 0950 3 Exp:RH-PD22



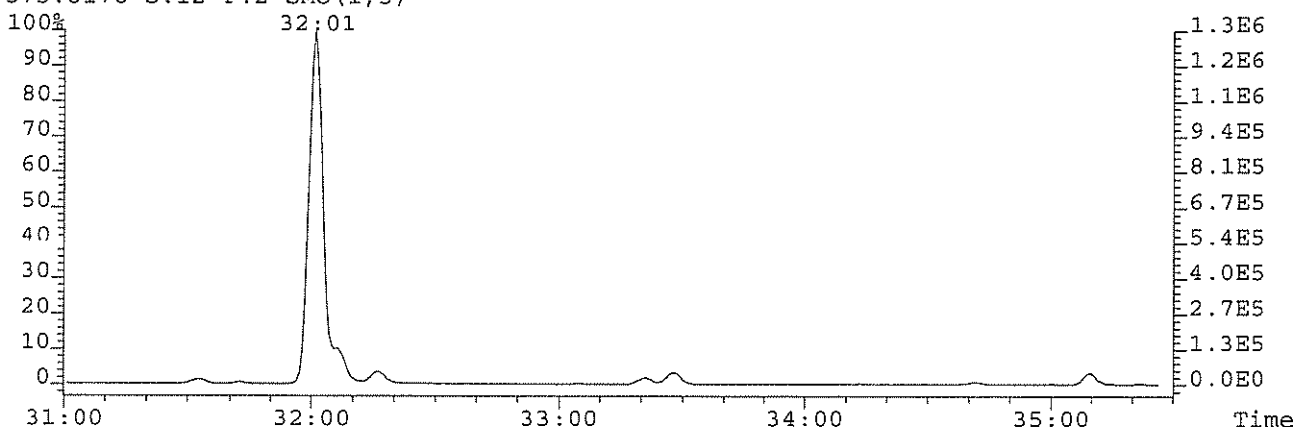
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130711-2 #1-648 Acq:12-JUL-2013 03:57:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#12 File Text:RH-12ms(5-8,nP) Text:XE13 0950 3 Exp:RH-PD22

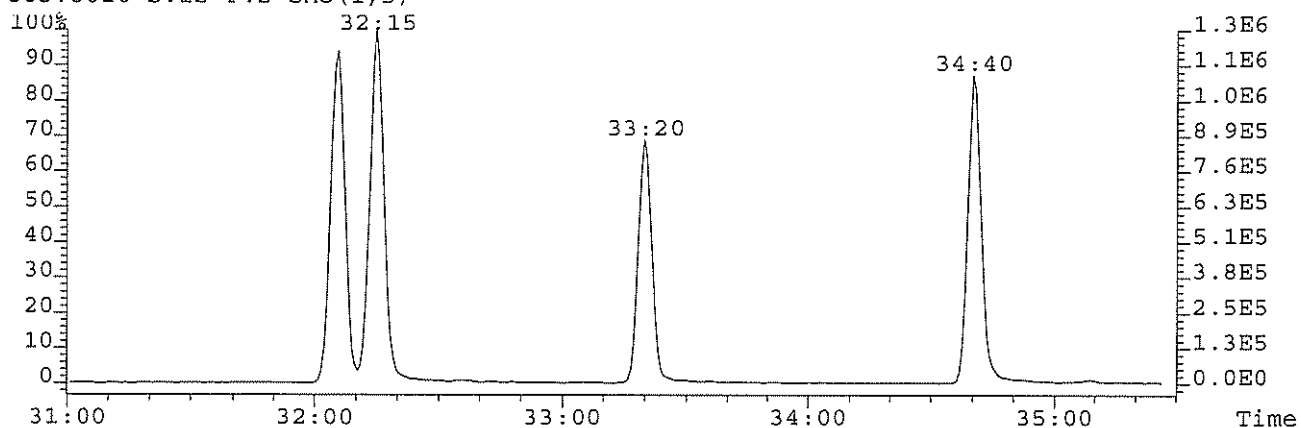
373.8207 S:12 F:2 SMO(1,3)



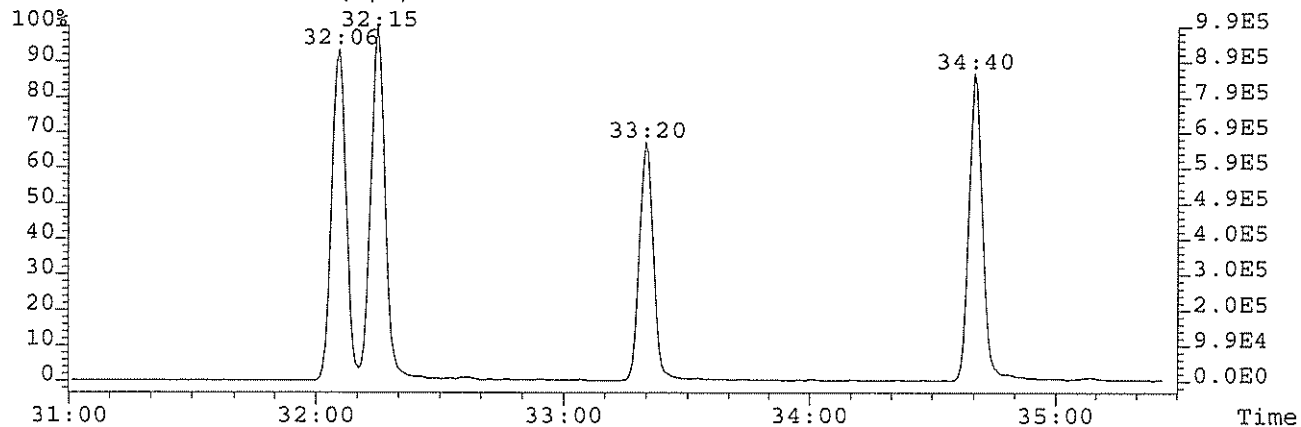
375.8178 S:12 F:2 SMO(1,3)



385.8610 S:12 F:2 SMO(1,3)



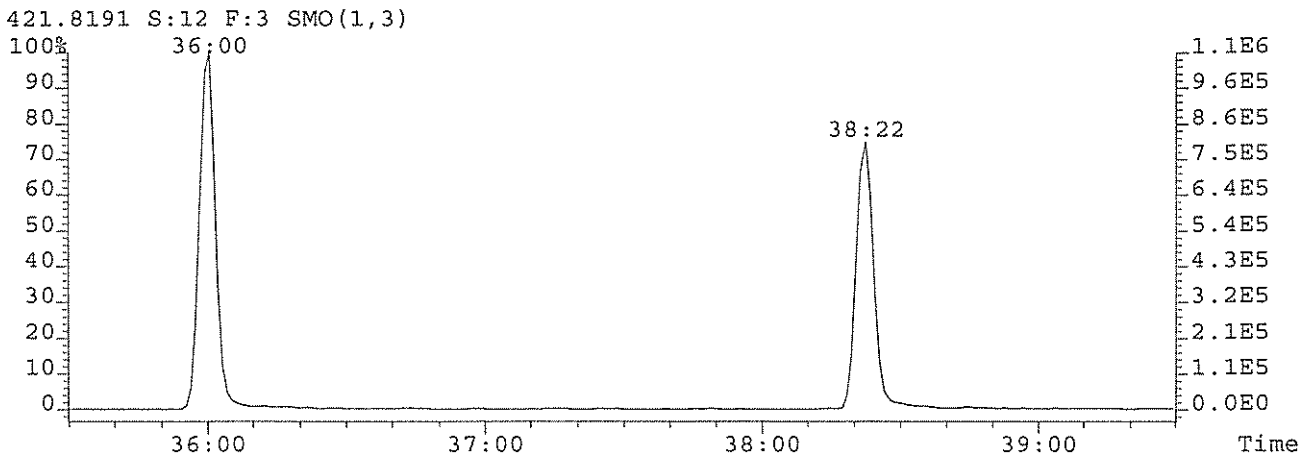
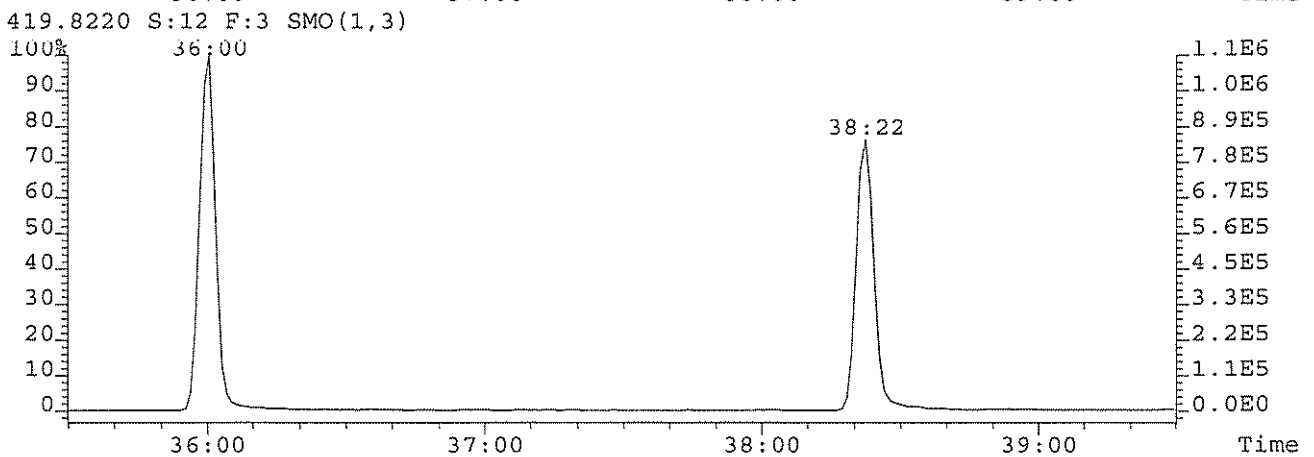
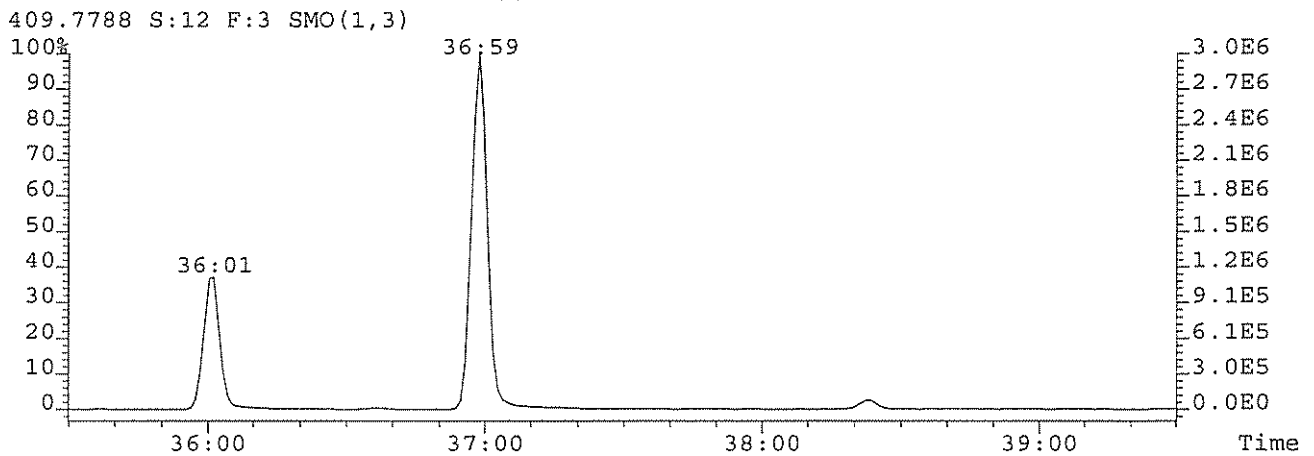
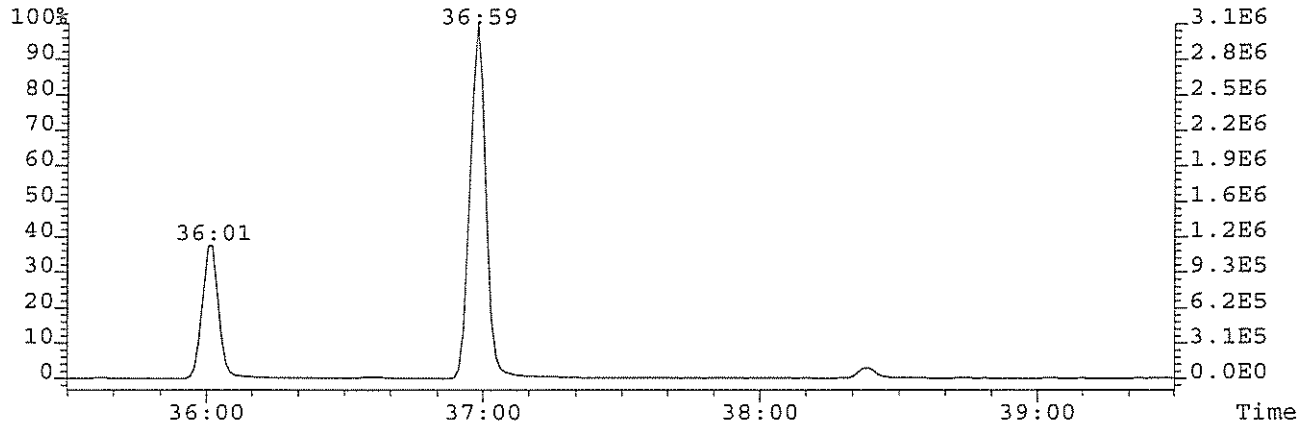
387.8580 S:12 F:2 SMO(1,3)



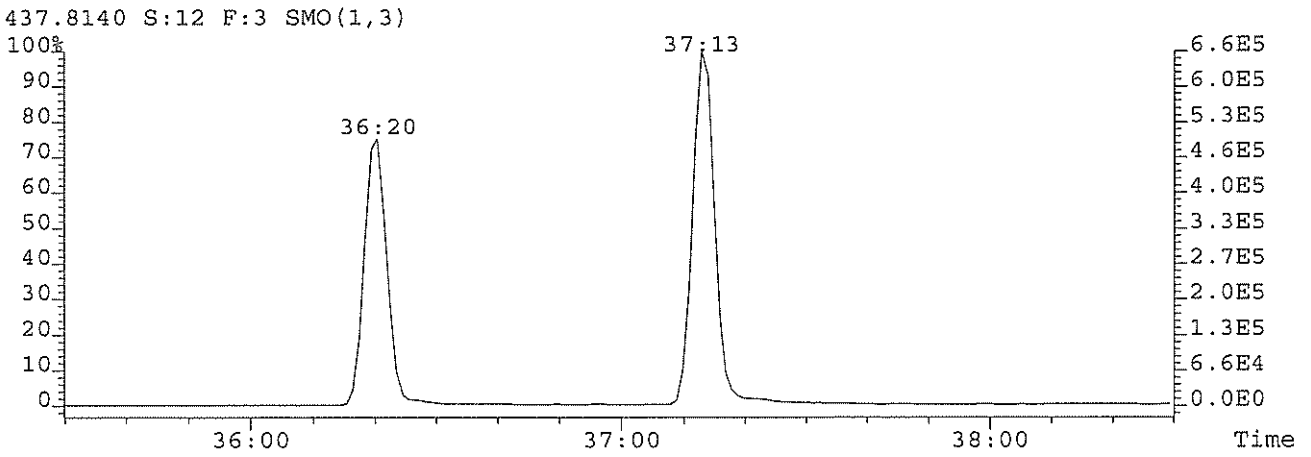
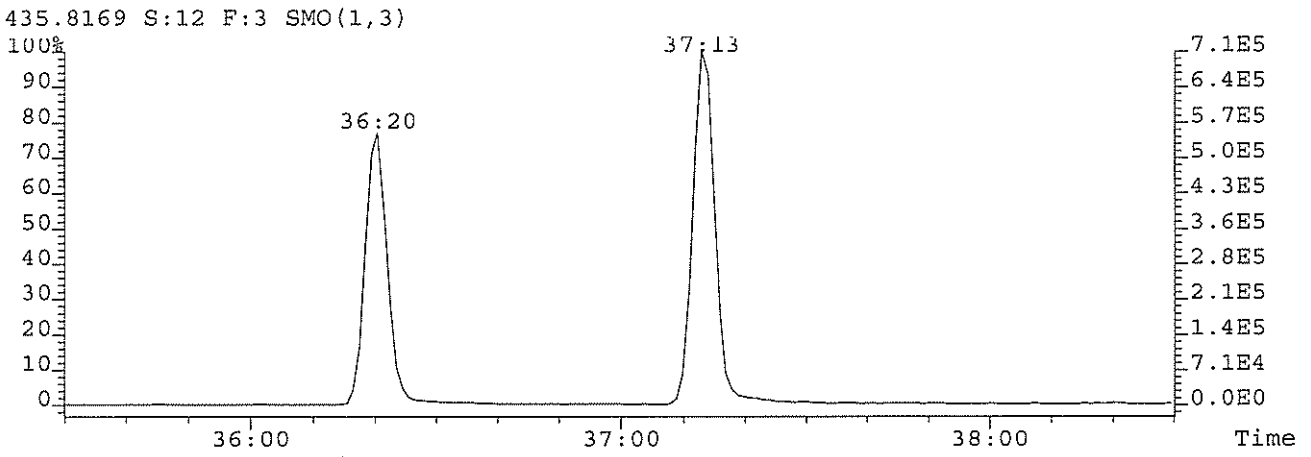
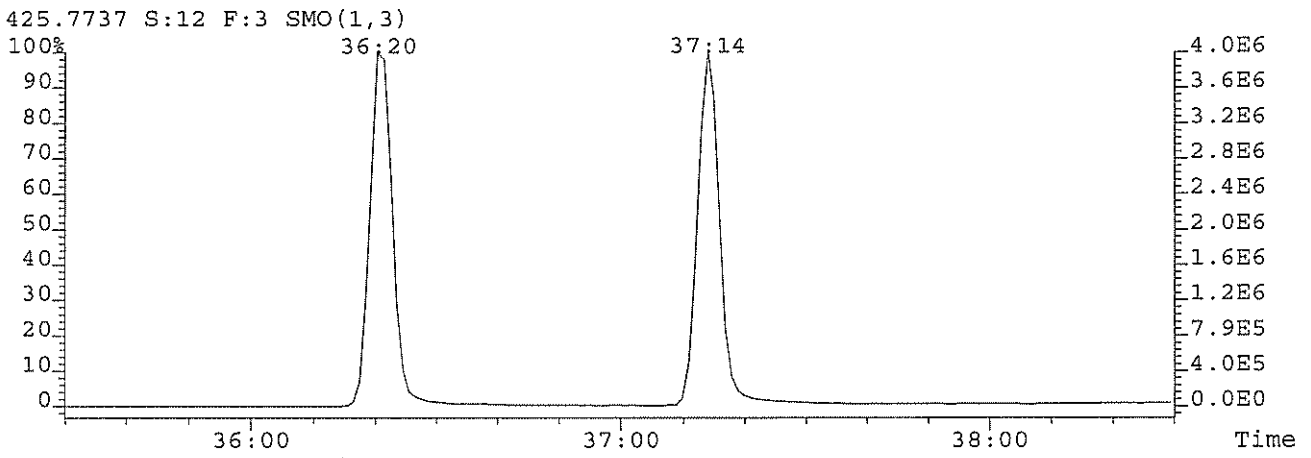
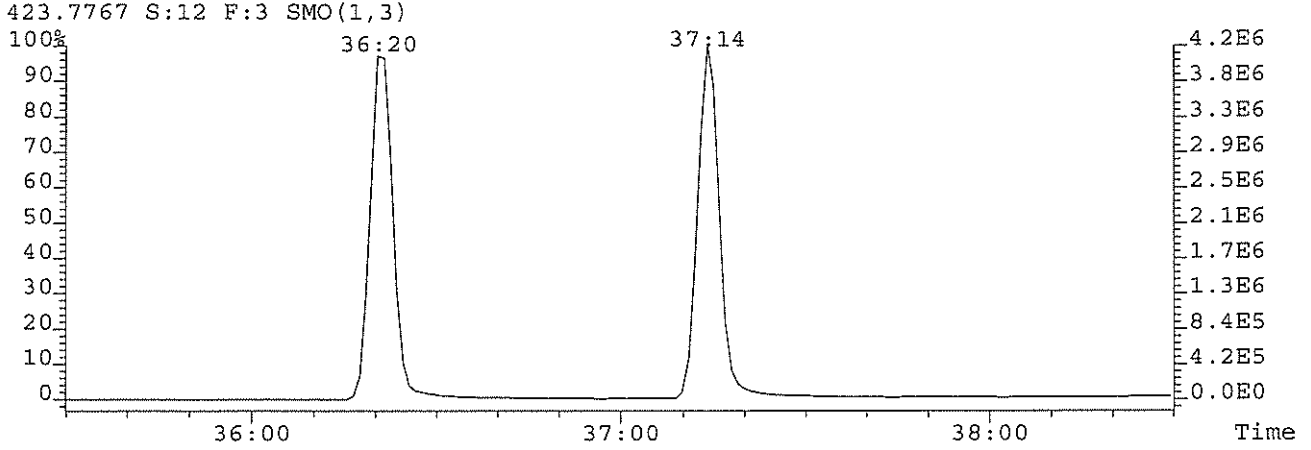
HxCDFsクロマトグラム (8)  
(123789-HxCDF)



File:130711-2 #1-563 Acq:12-JUL-2013 03:57:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#12 File Text:RH-12ms(5-8,nP) Text:XE13 0950 3 Exp:RH-PD22  
407.7818 S:12 F:3 SMO(1,3)

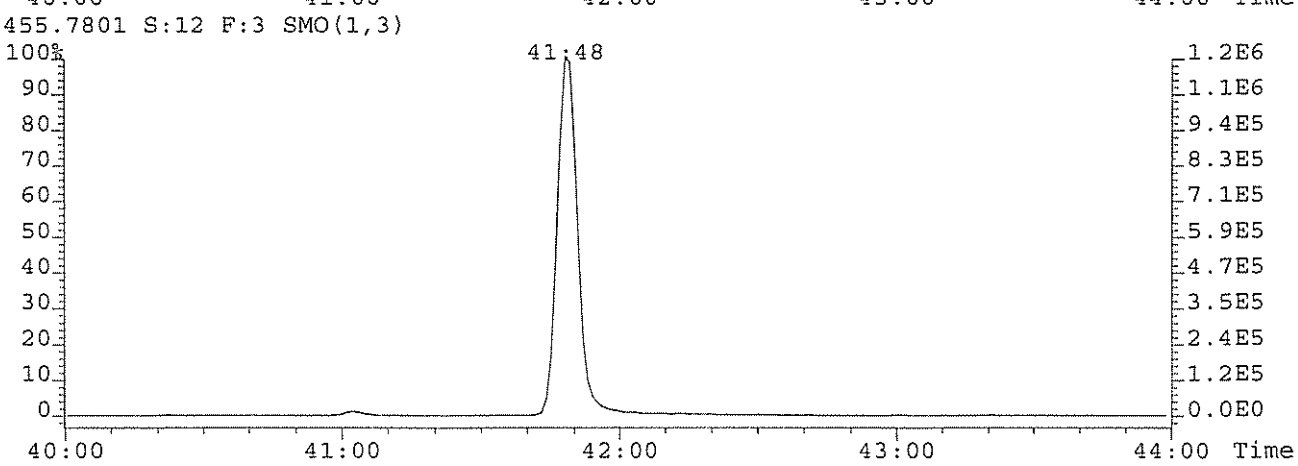
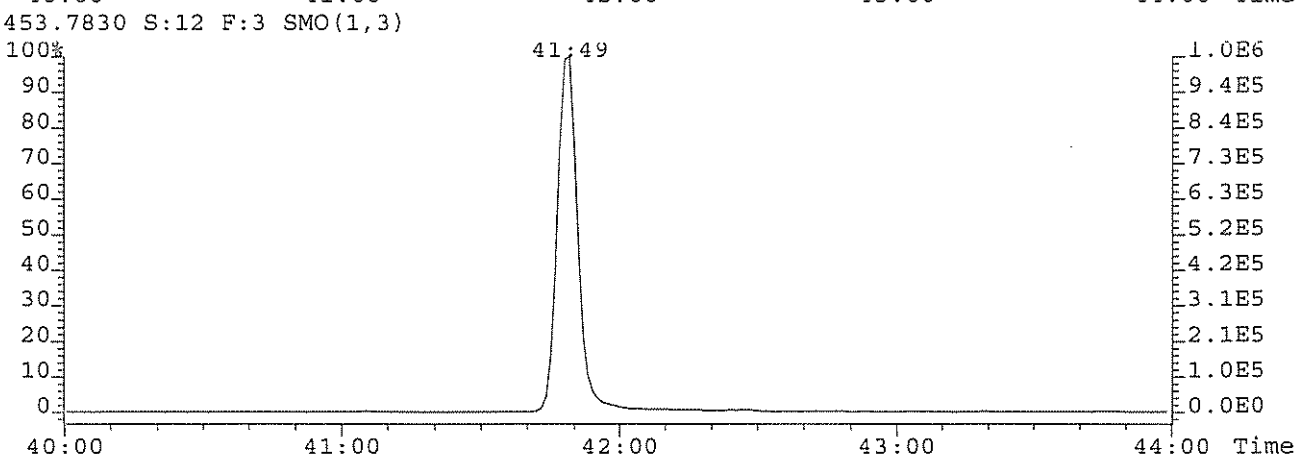
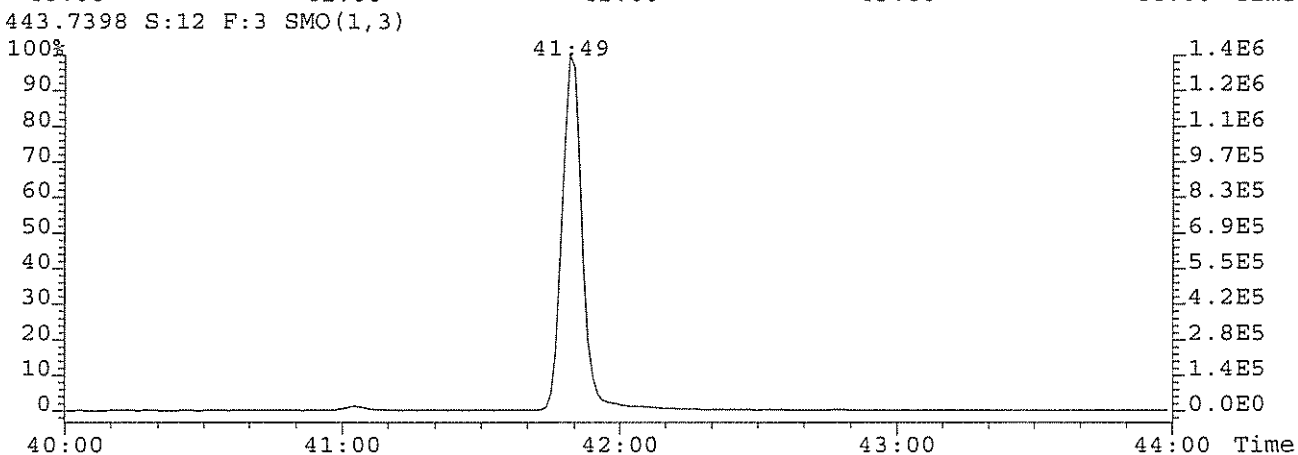
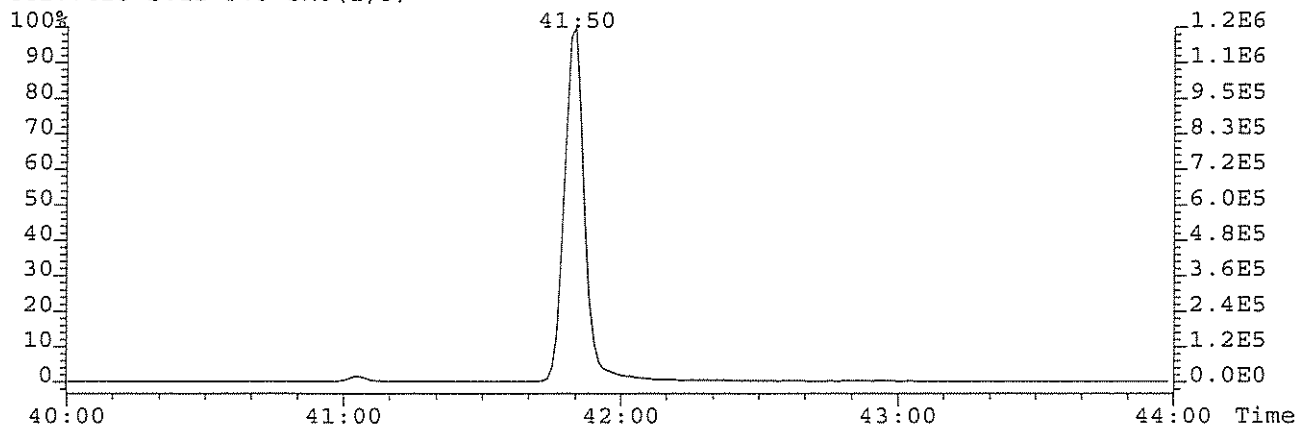


File:130711-2 #1-563 Acq:12-JUL-2013 03:57:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#12 File Text:RH-12ms(5-8,nP) Text:XE13 0950 3 Exp:RH-PD22



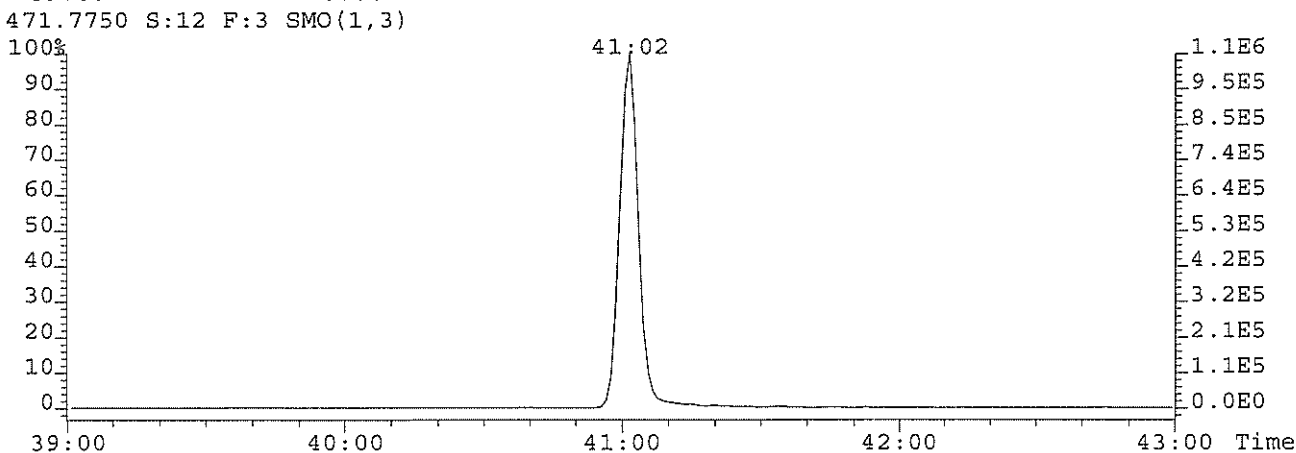
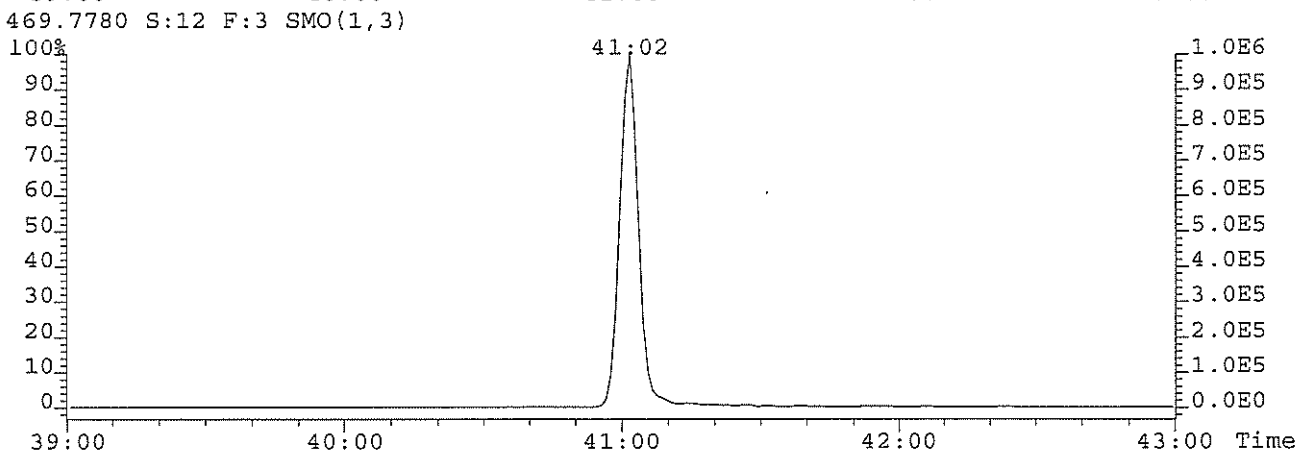
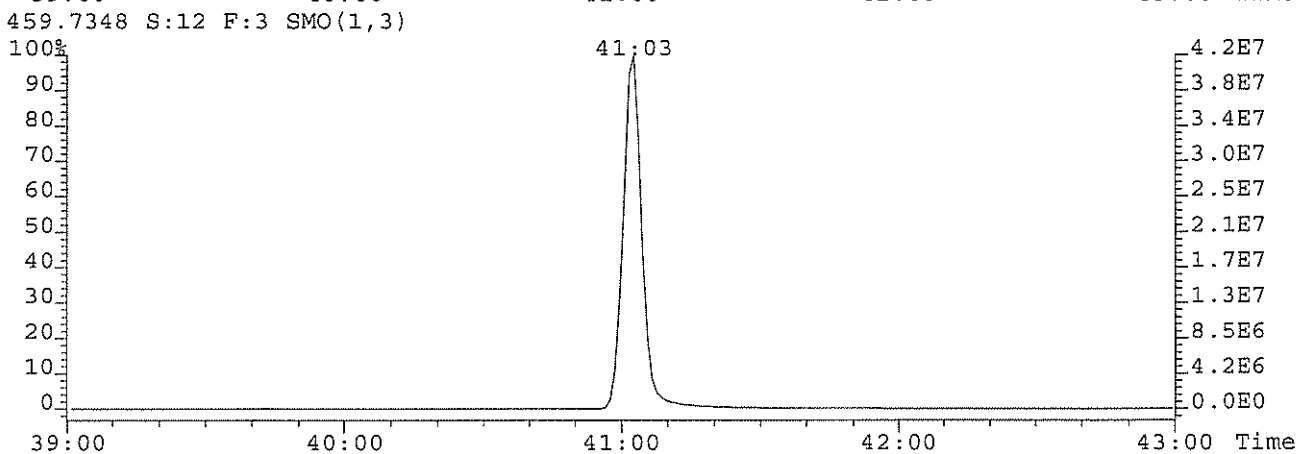
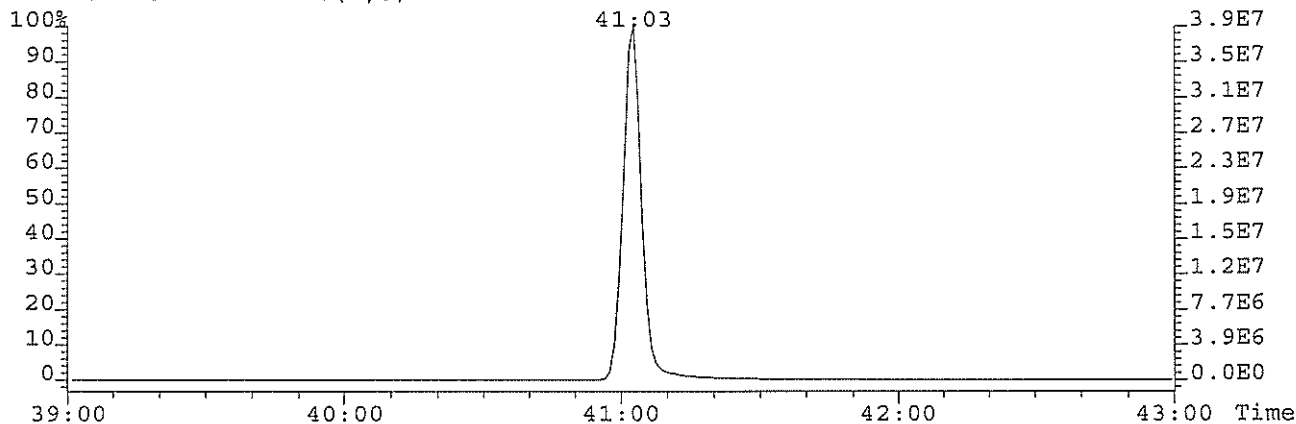
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130711-2 #1-563 Acq:12-JUL-2013 03:57:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#12 File Text:RH-12ms(5-8,nP) Text:XE13 0950 3 Exp:RH-PD22  
441.7428 S:12 F:3 SMO(1,3)



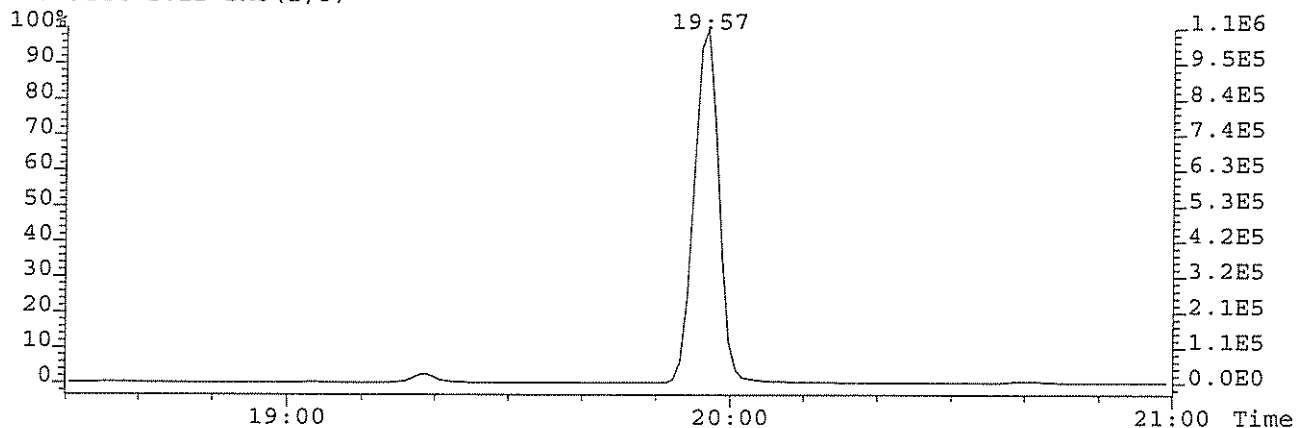
PCDFsクロマトグラム (11)  
(OCDF)

File:130711-2 #1-563 Acq:12-JUL-2013 03:57:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#12 File Text:RH-12ms(5-8,nP) Text:XE13 0950 3 Exp:RH-PD22  
457.7377 S:12 F:3 SMO(1,3)

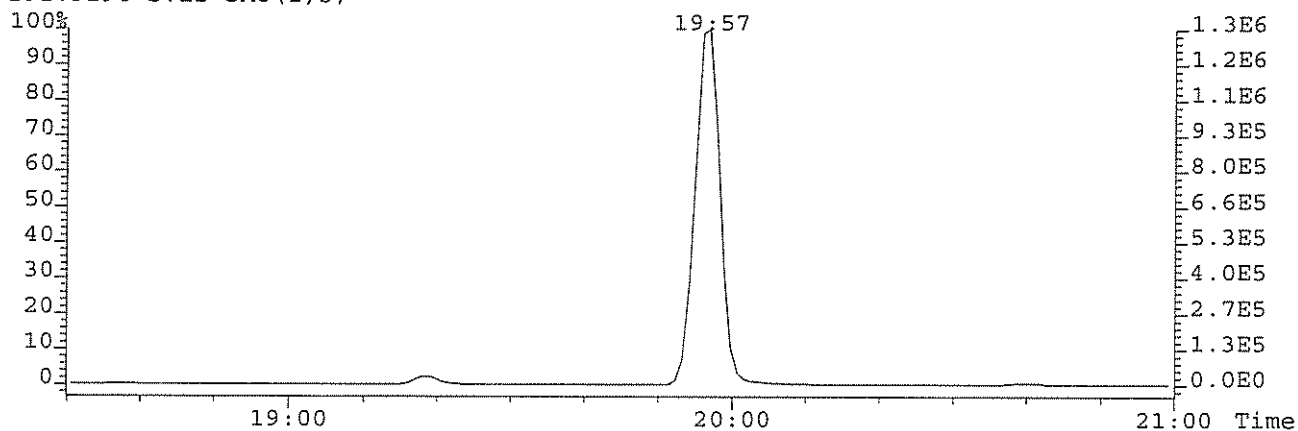


PCDDsクロマトグラム (12)  
(OCDD)

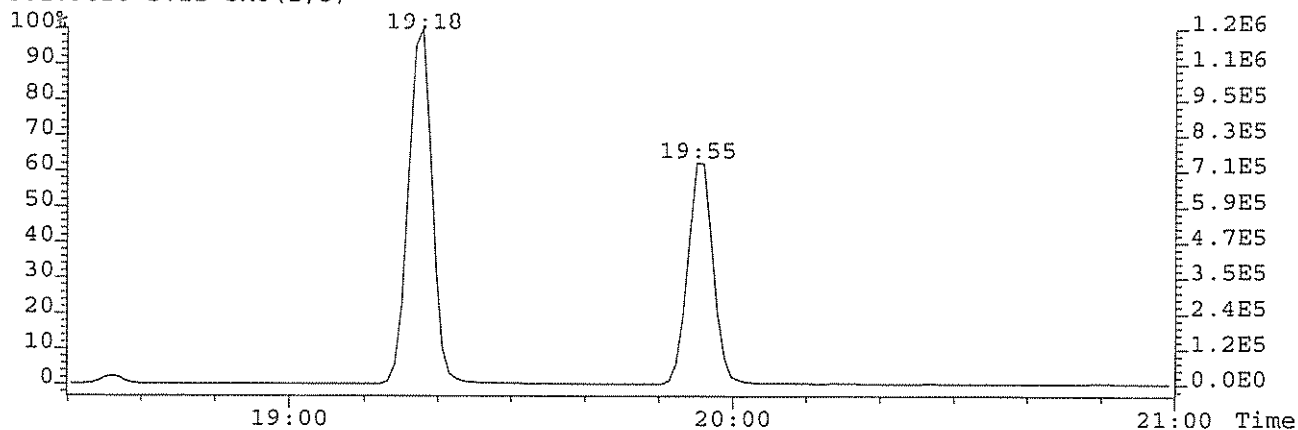
File:130711-2 #1-1430 Acq:12-JUL-2013 03:57:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#12 File Text:RH-12ms(5-8,nP) Text:XE13 0950 3 Exp:RH-PD22  
289.9224 S:12 SMO(1,3)



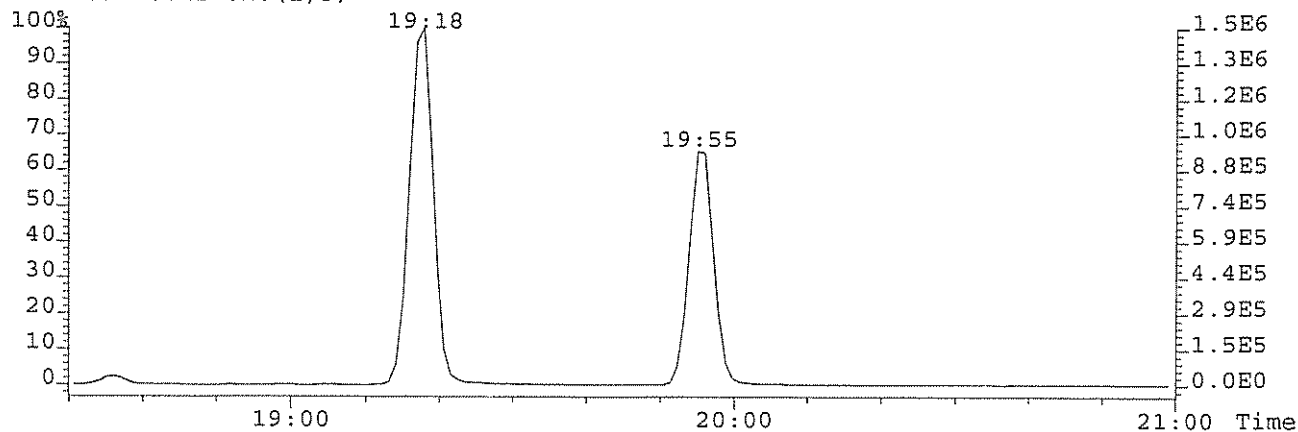
291.9194 S:12 SMO(1,3)



301.9626 S:12 SMO(1,3)

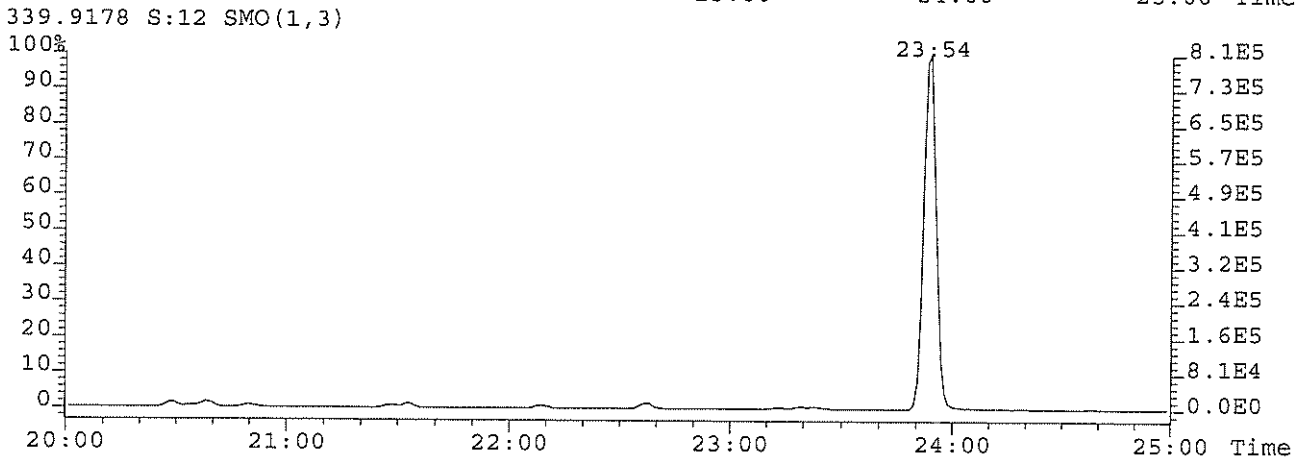
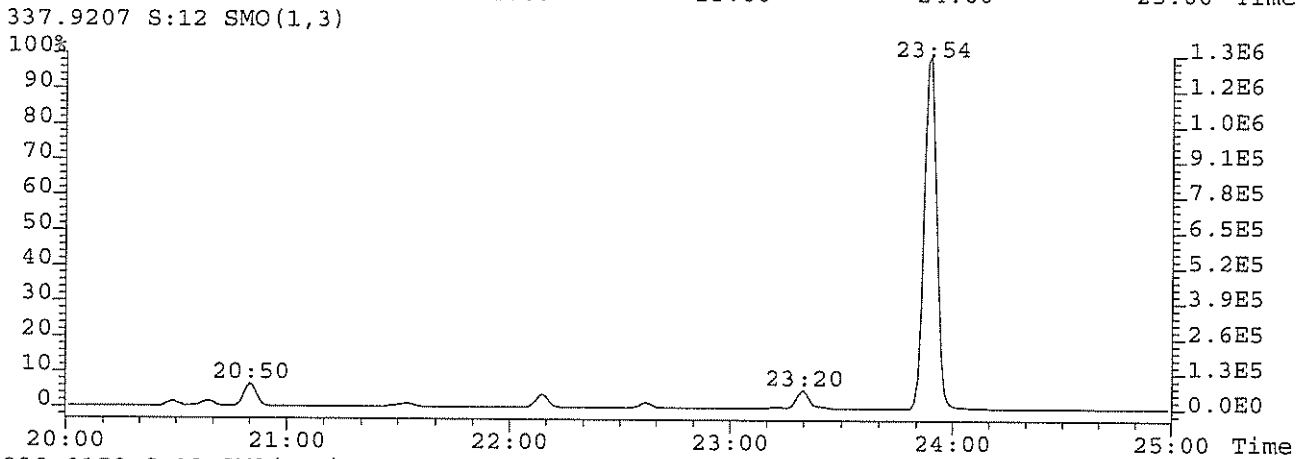
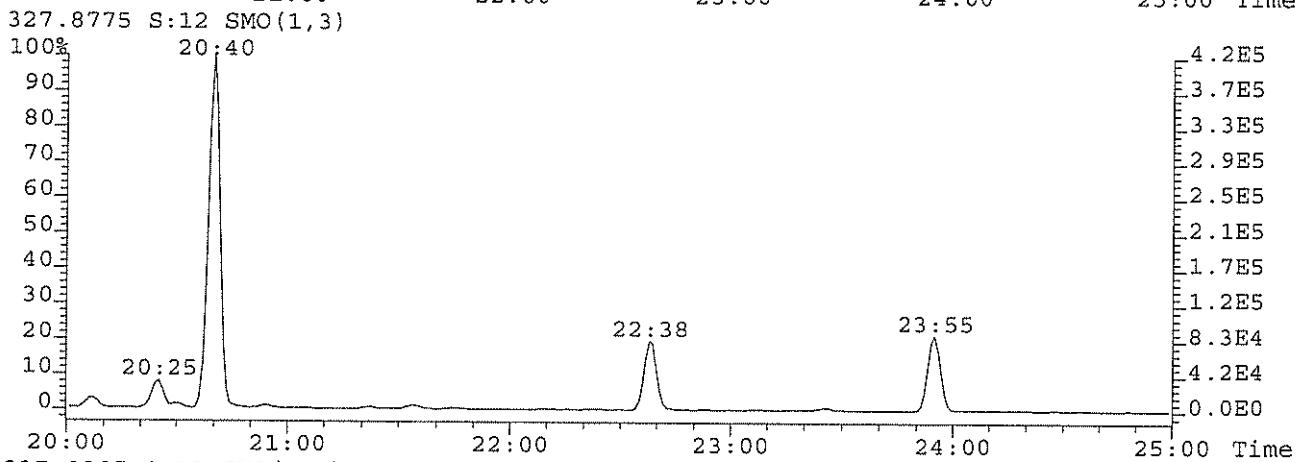
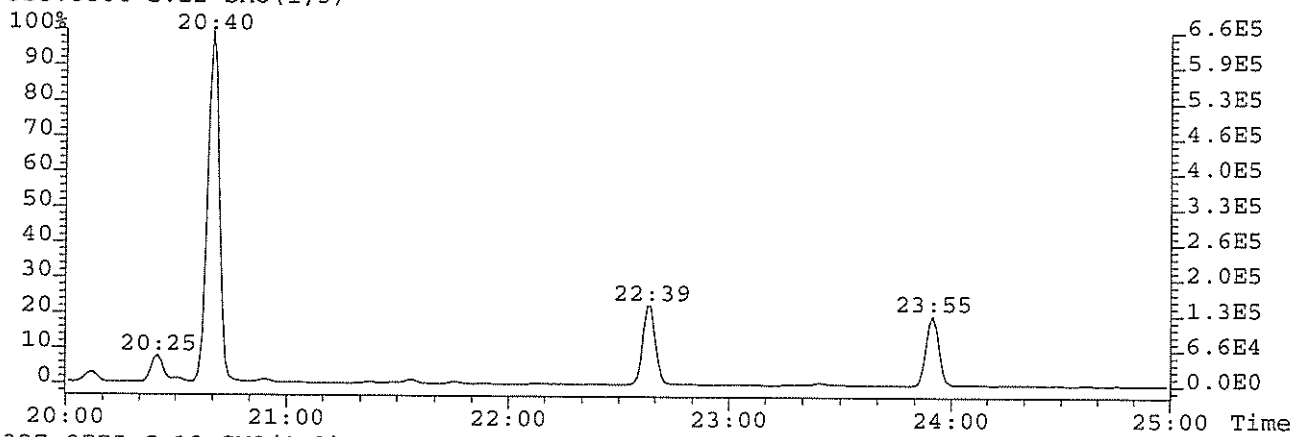


303.9597 S:12 SMO(1,3)



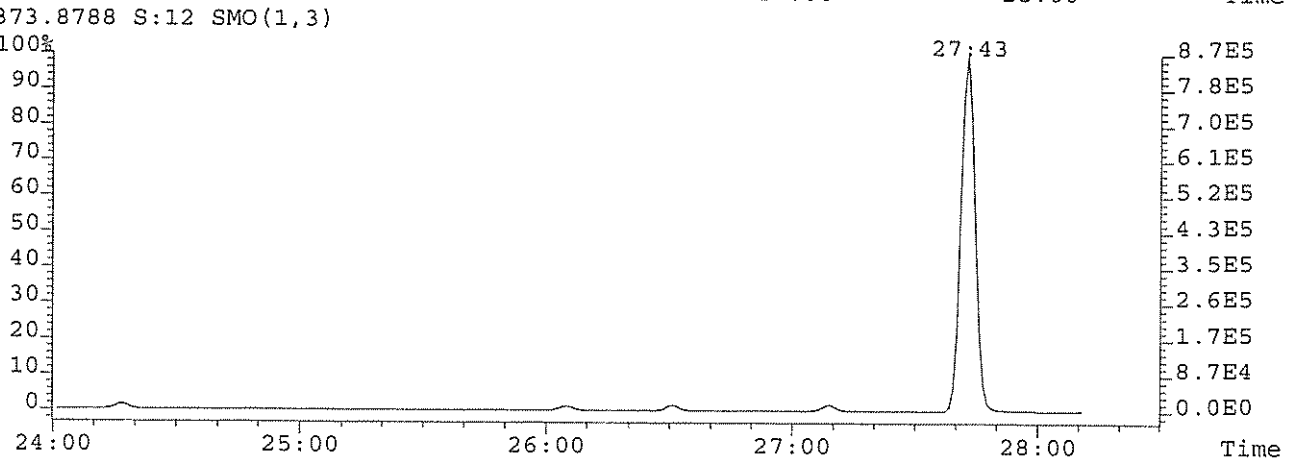
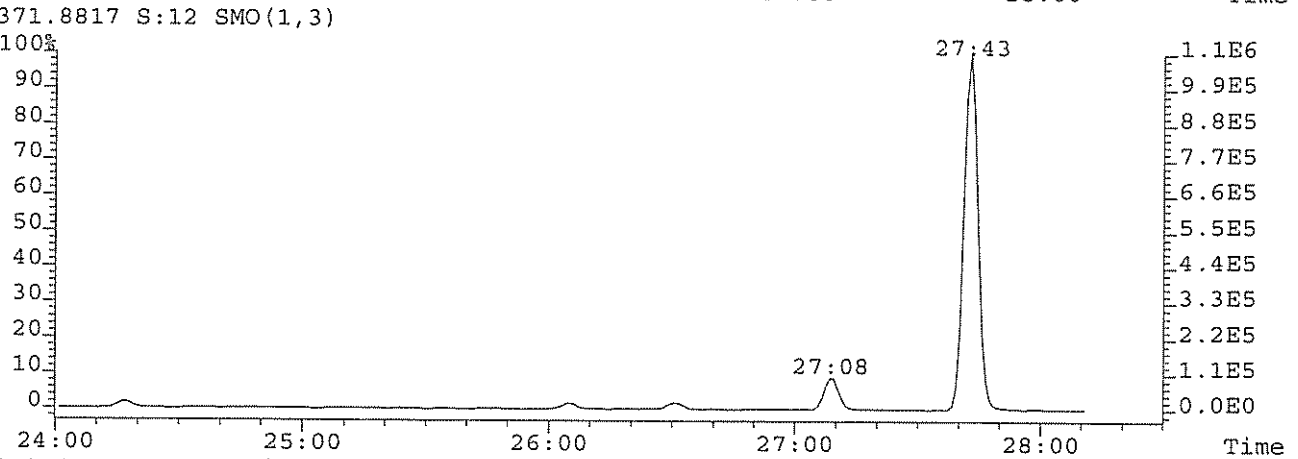
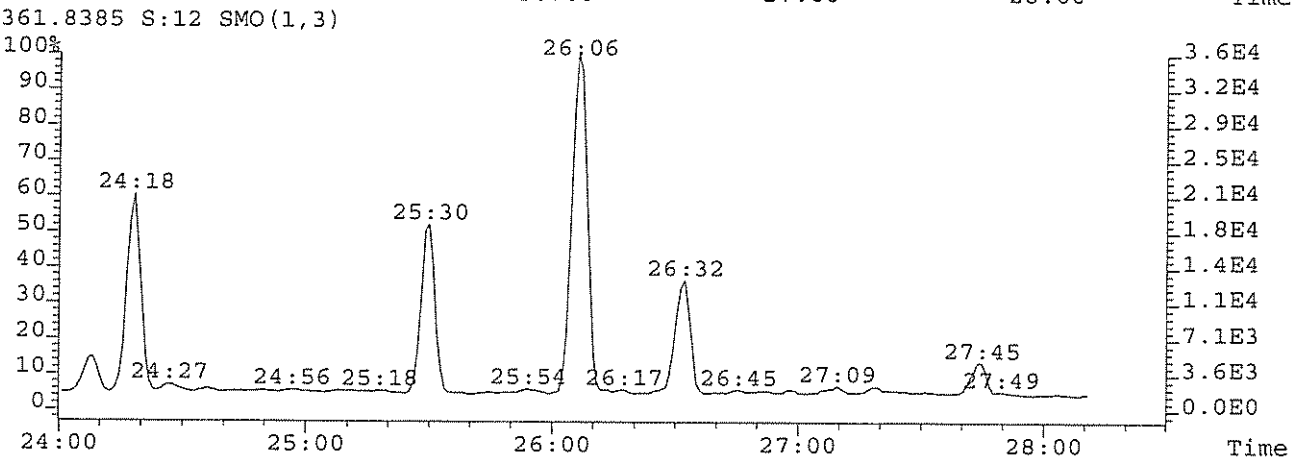
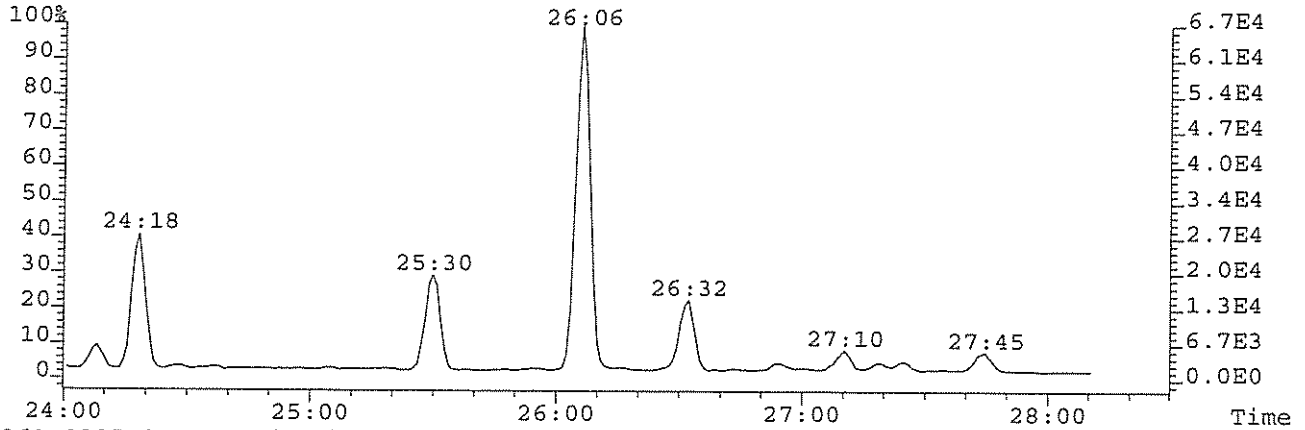
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 03:57:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#12 File Text:RH-12ms(5-8,nP) Text:XE13 0950 3 Exp:RH-PD22



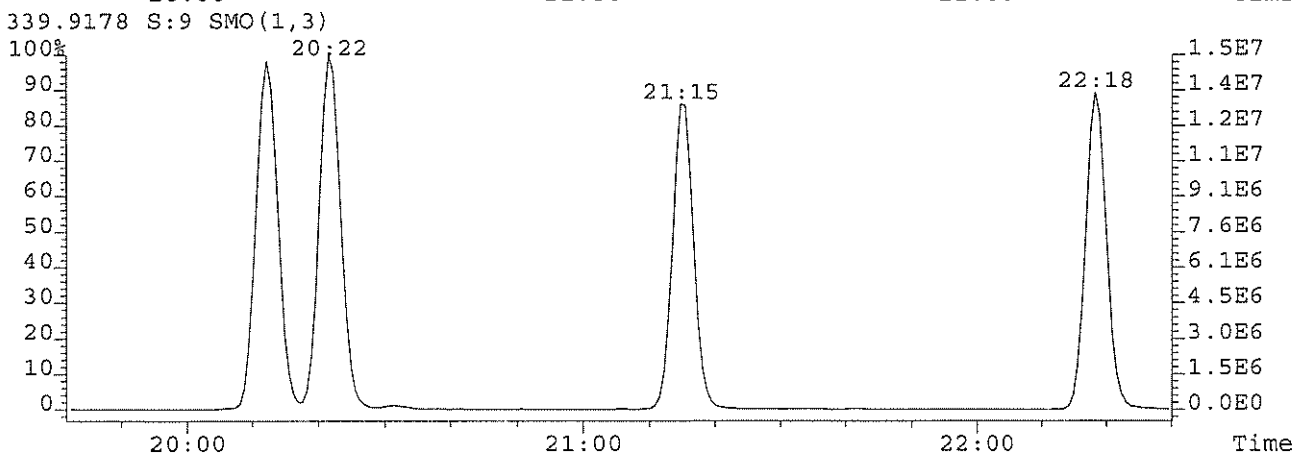
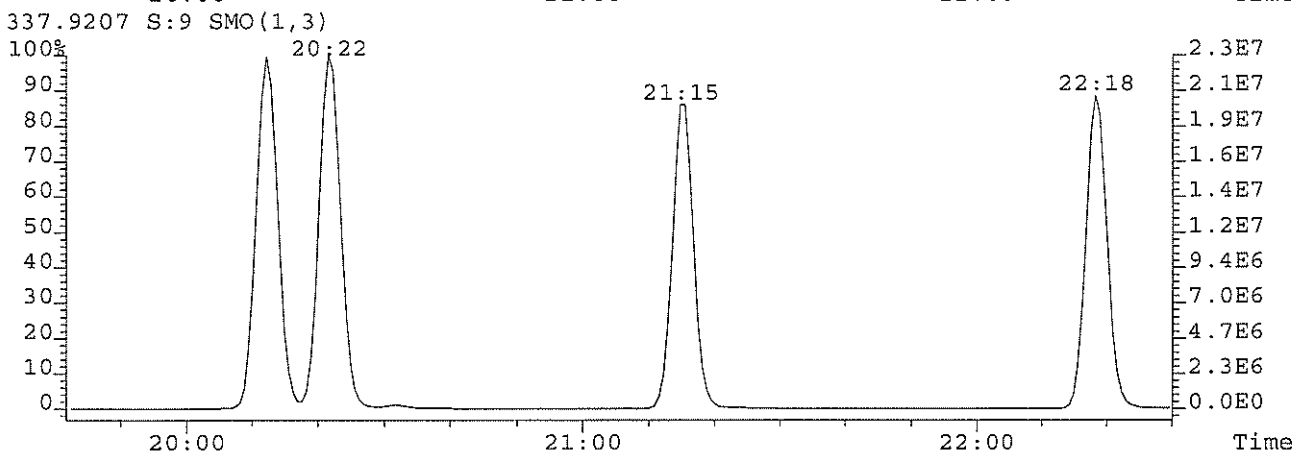
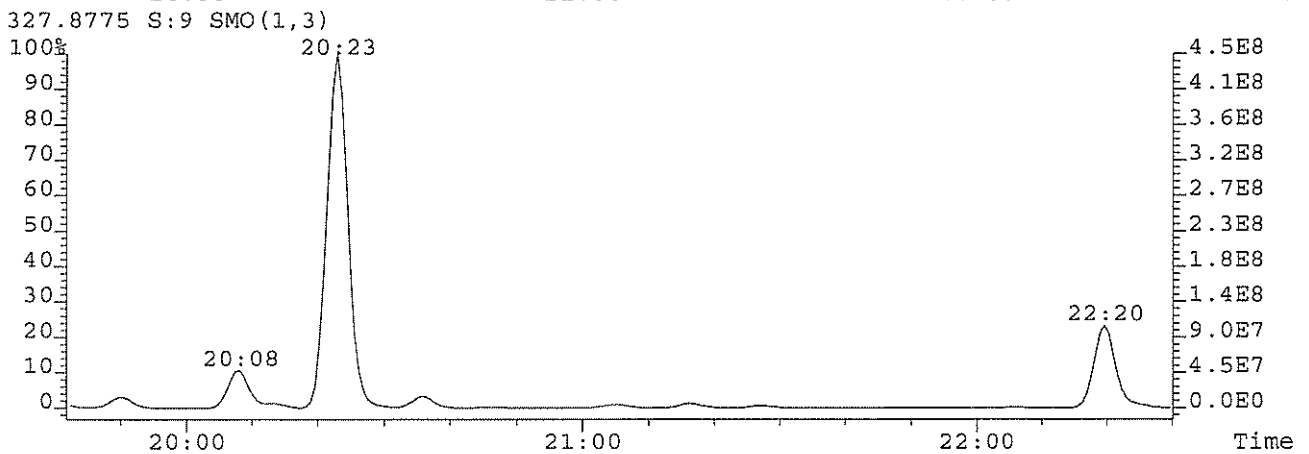
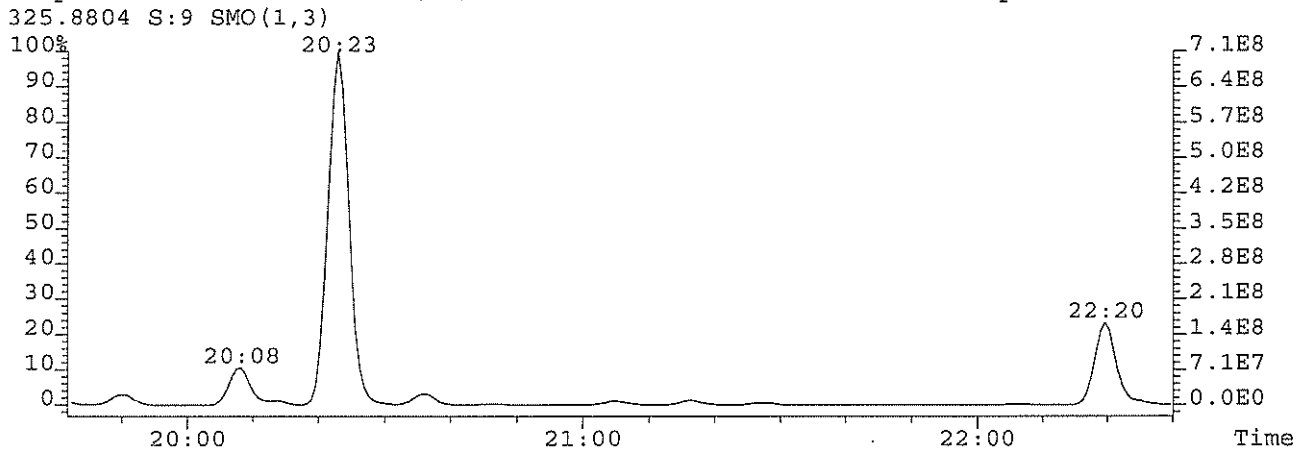
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 03:57:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#12 File Text:RH-12ms(5-8,nP) Text:XE13 0950 3 Exp:RH-PD22  
359.8415 S:12 SMO(1,3)



DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

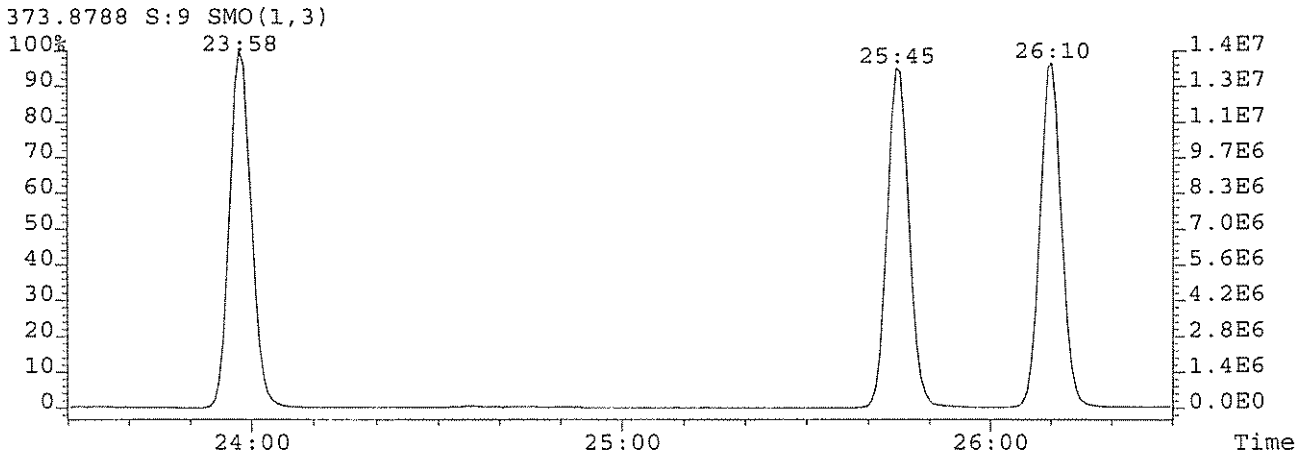
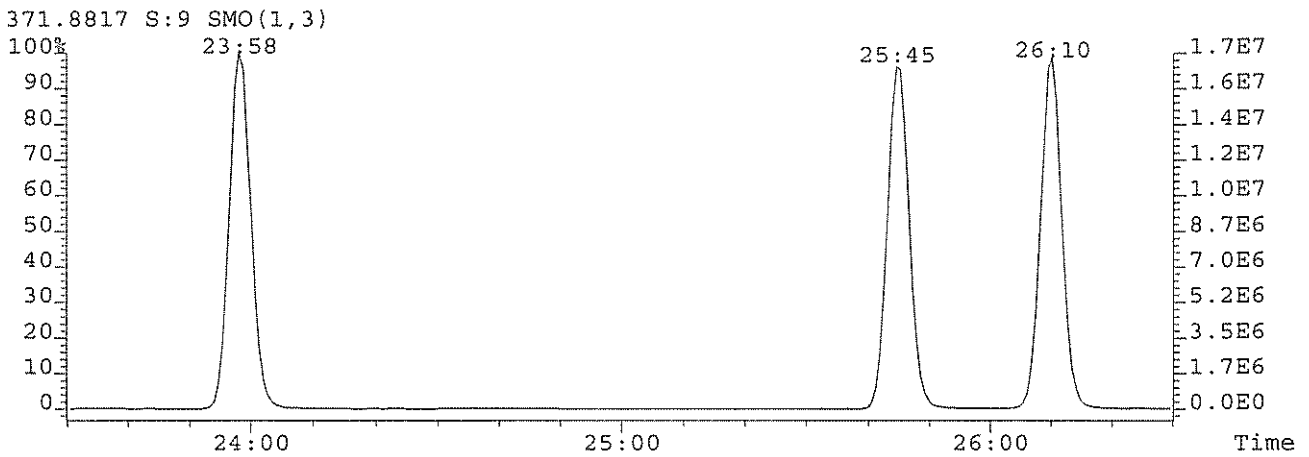
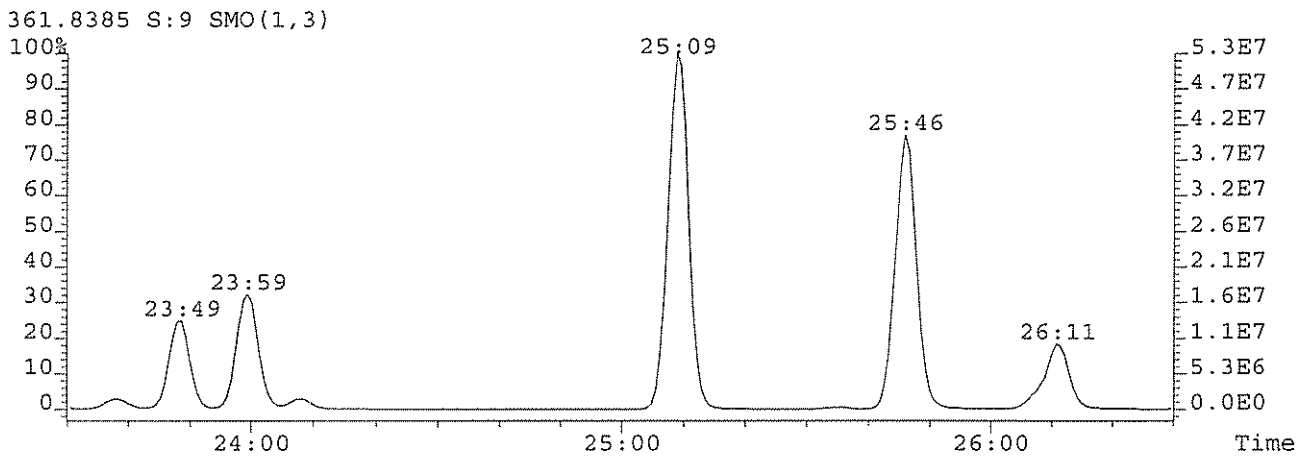
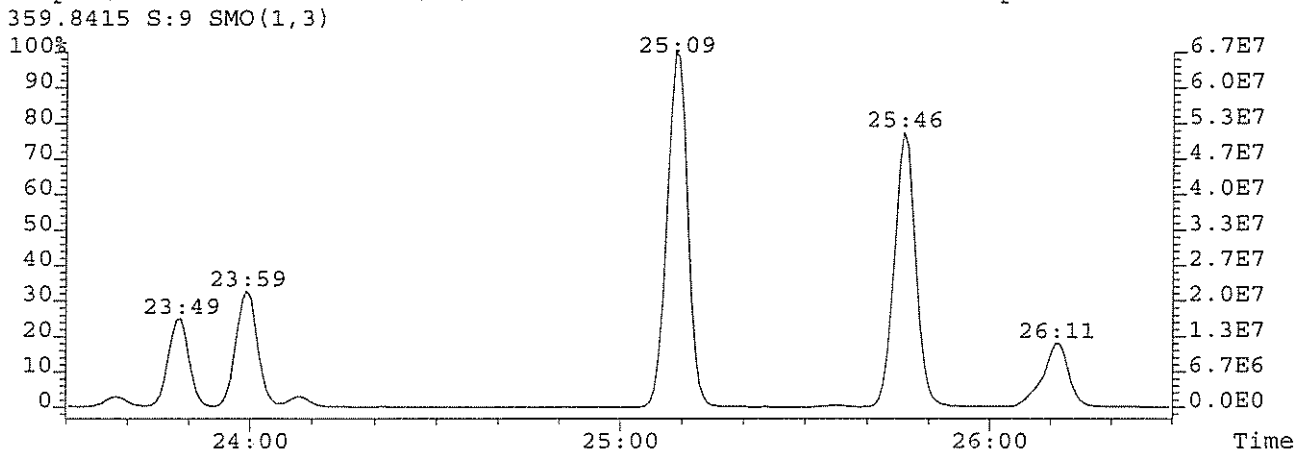
File:130711-2 #1-2897 Acq:11-JUL-2013 23:29:18 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#9 File Text:RH-12ms(mP) Text:XE13 0950 2 Exp:RH-MP11



DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

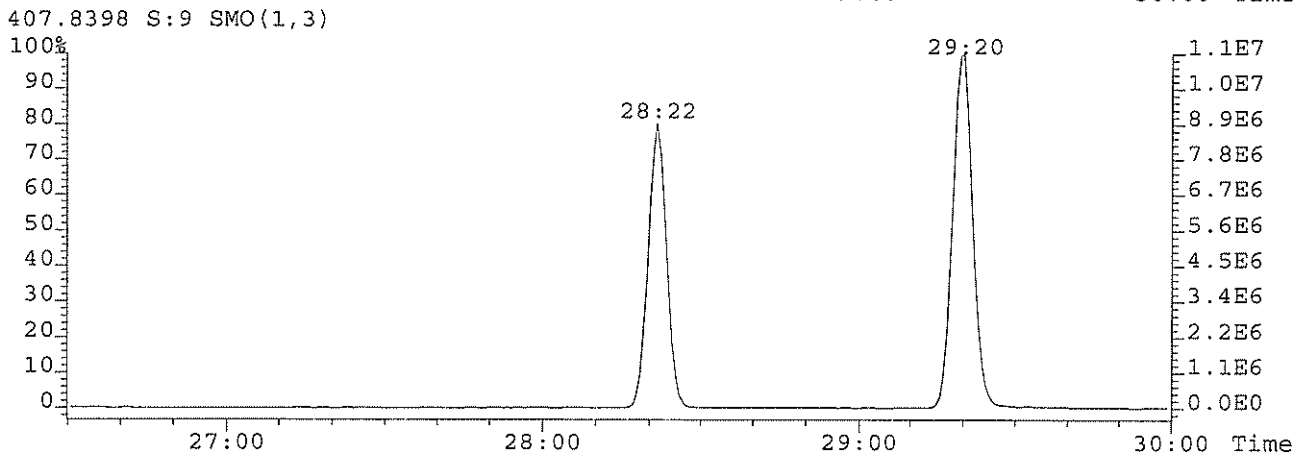
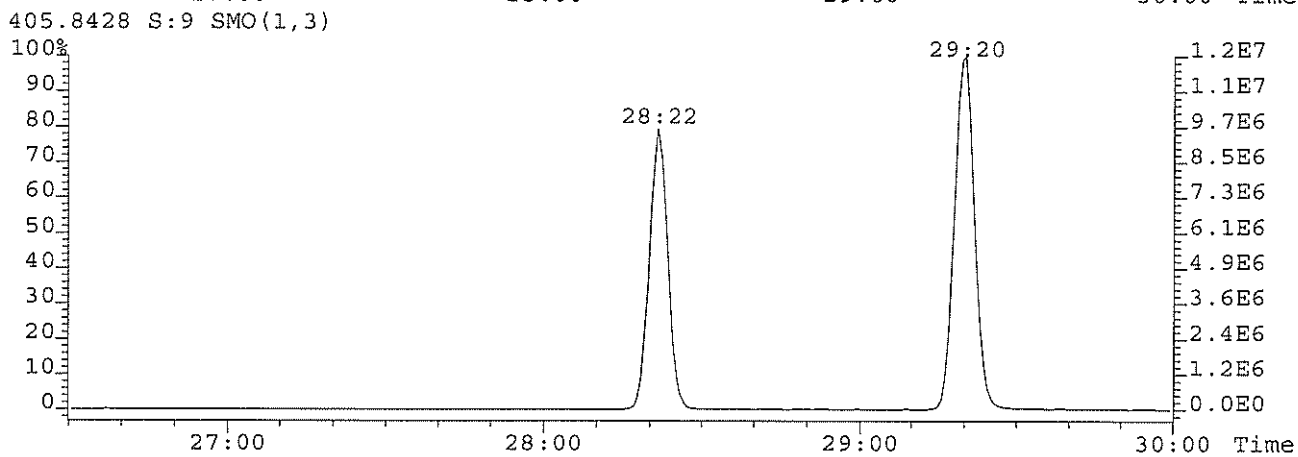
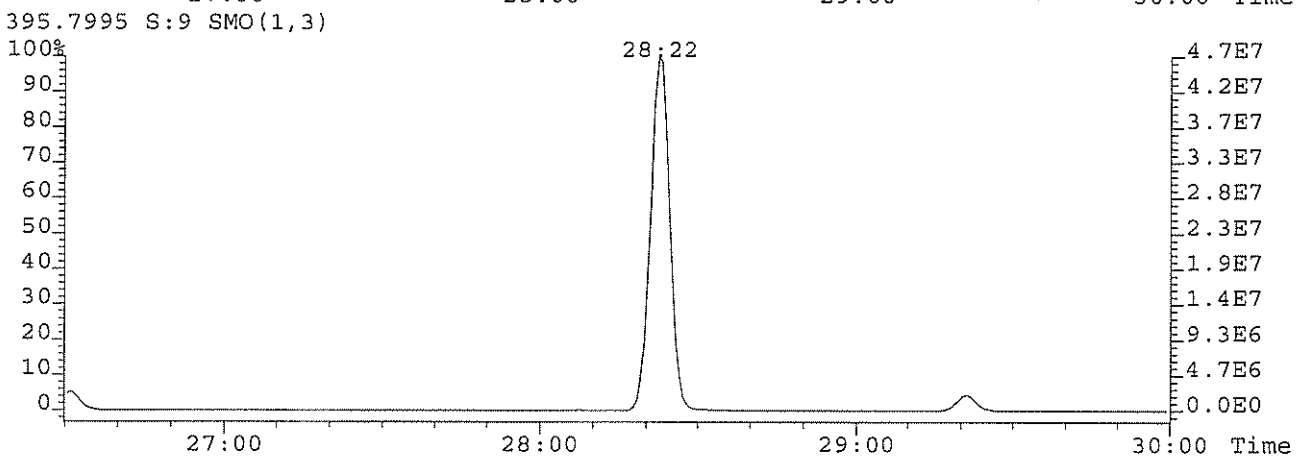
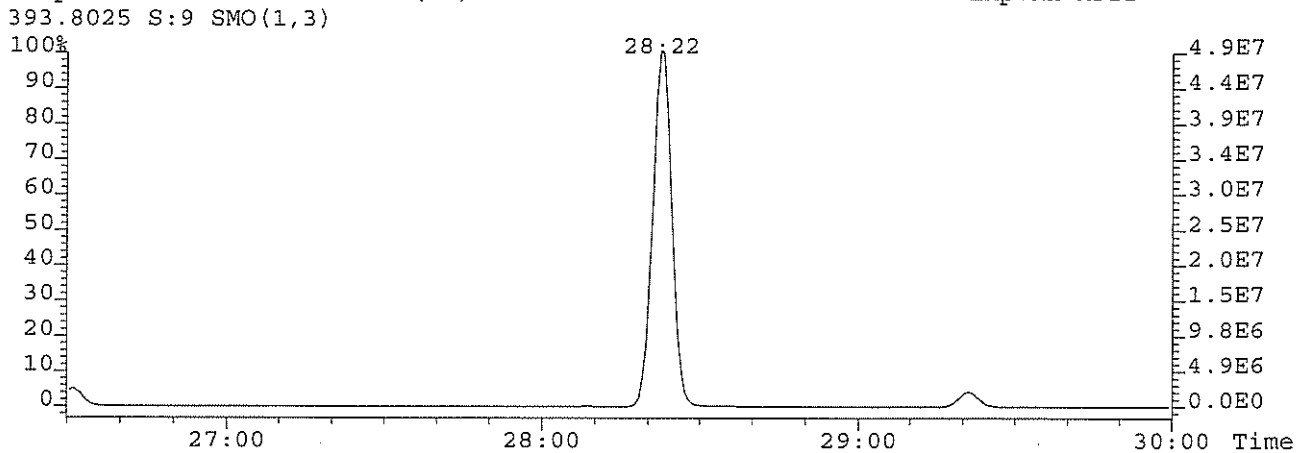


File:130711-2 #1-2897 Acq:11-JUL-2013 23:29:18 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#9 File Text:RH-12ms(mP) Text:XE13 0950 2 Exp:RH-MP11



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

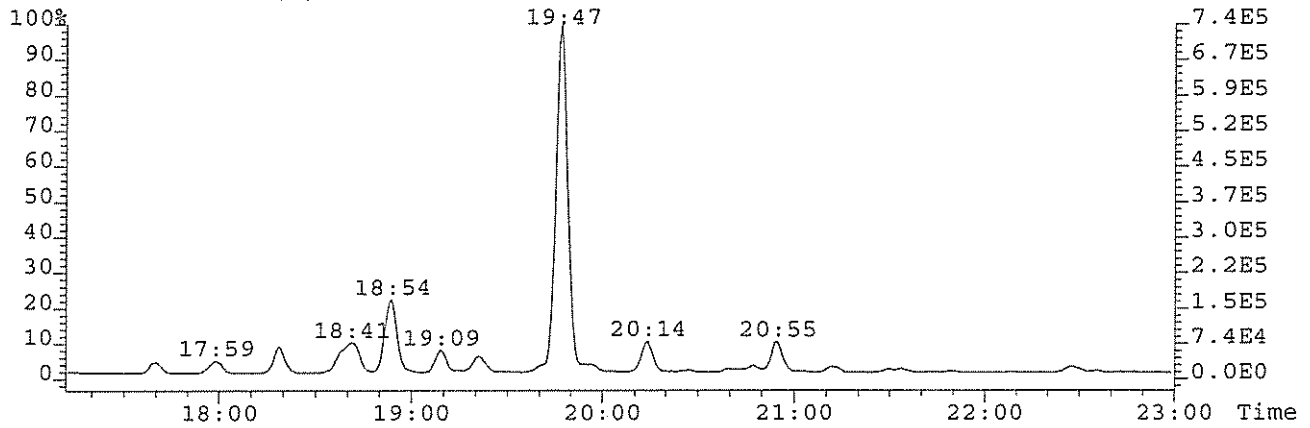
File:130711-2 #1-2897 Acq:11-JUL-2013 23:29:18 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#9 File Text:RH-12ms(mP) Text:XE13 0950 2 Exp:RH-MP11



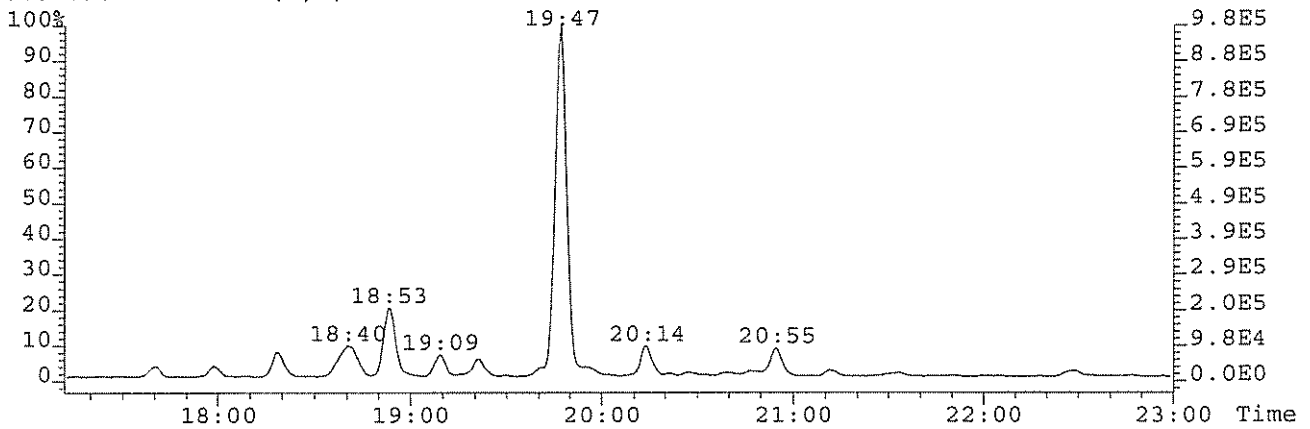
DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

試料管理番号	XE 130951
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.5

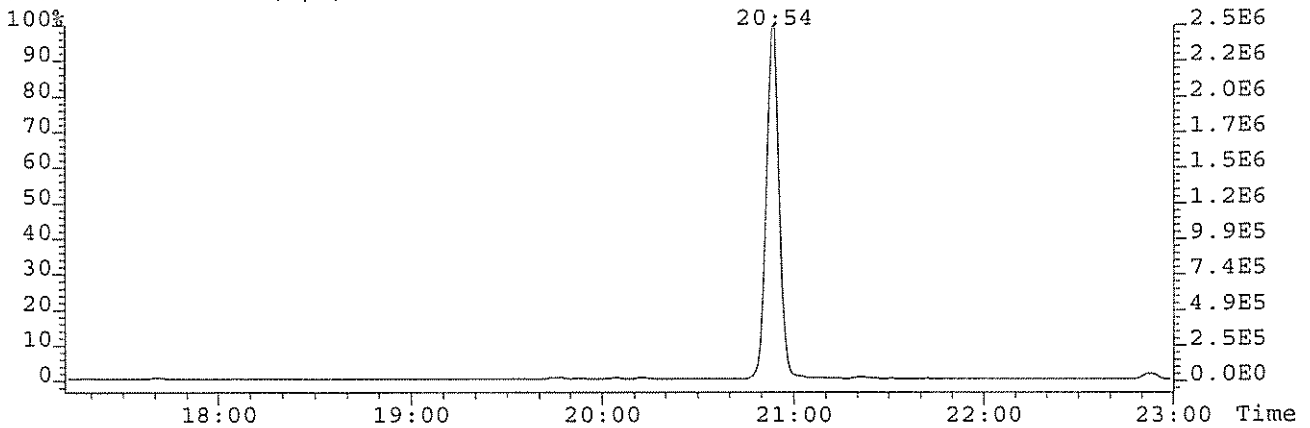
File:130710-2 #1-1578 Acq:11-JUL-2013 07:16:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:BPX-DXN(4-6DXN) Text:XE13 0951 Exp:BPX04  
303.9016 S:21 SMO(1,3)



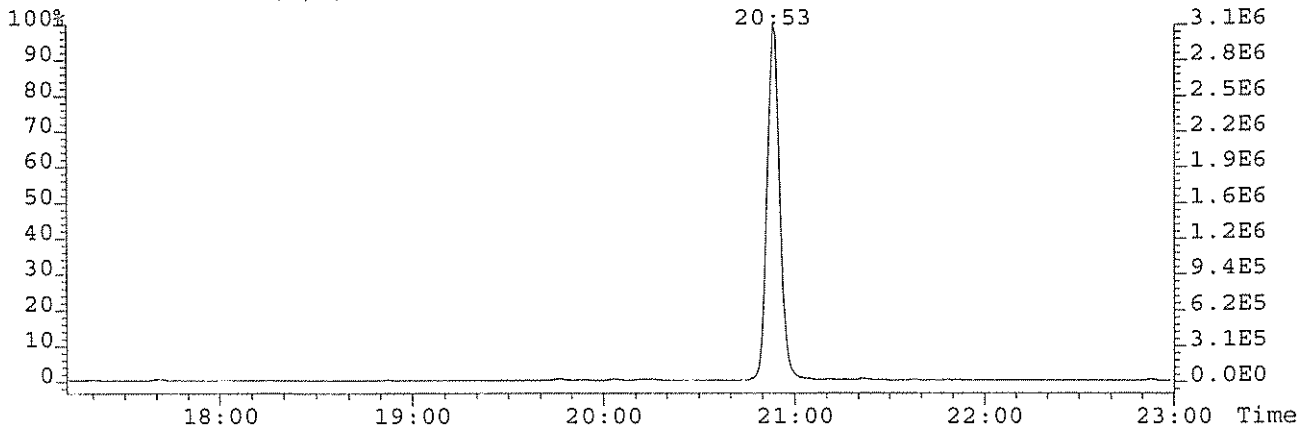
305.8987 S:21 SMO(1,3)



315.9419 S:21 SMO(1,3)

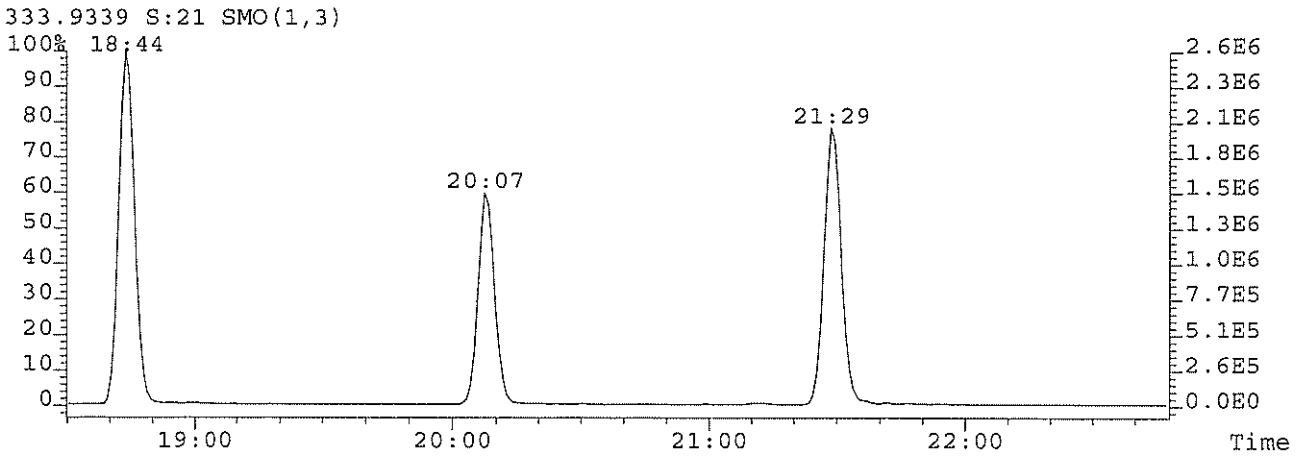
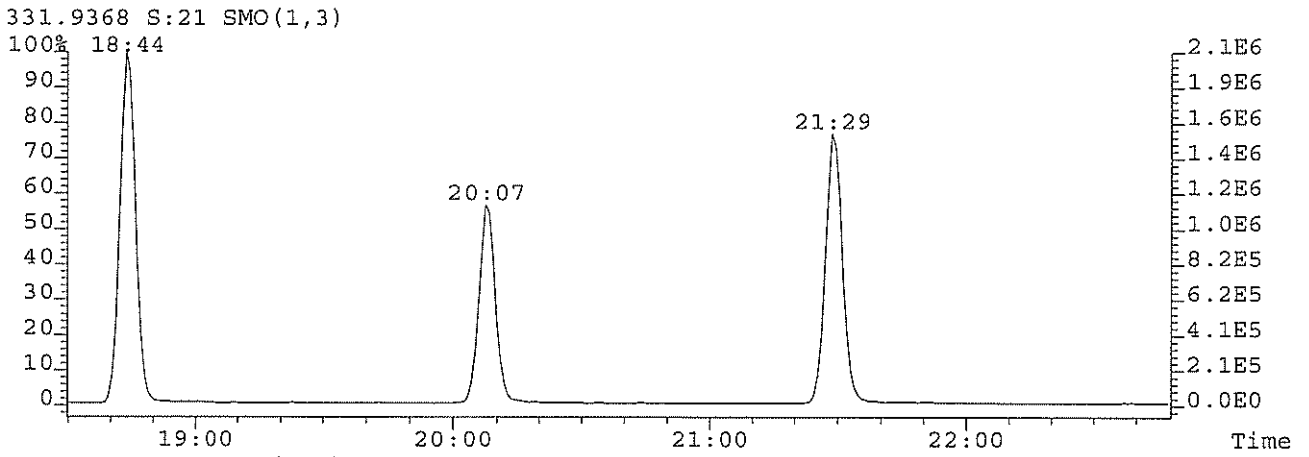
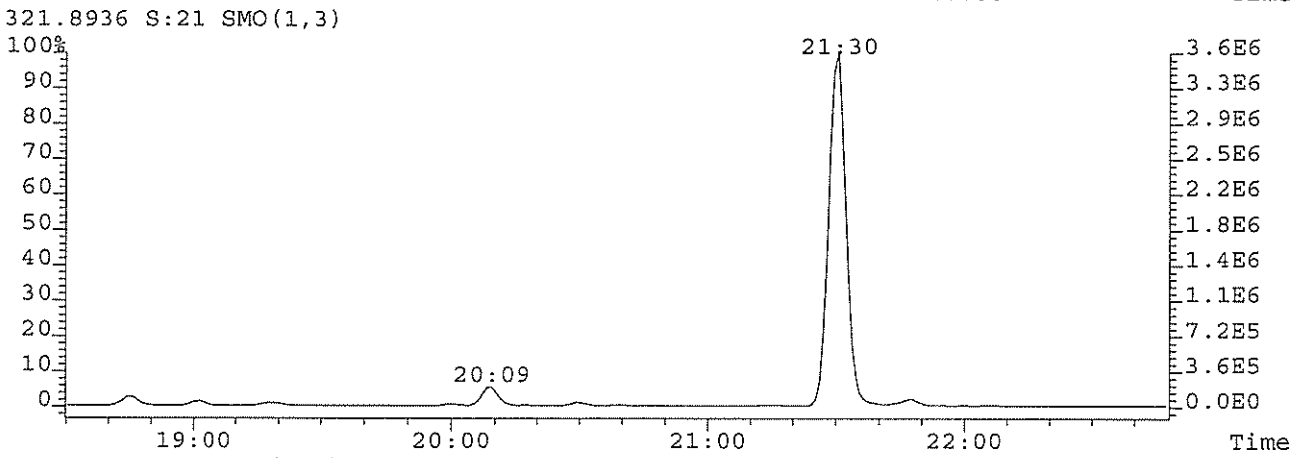
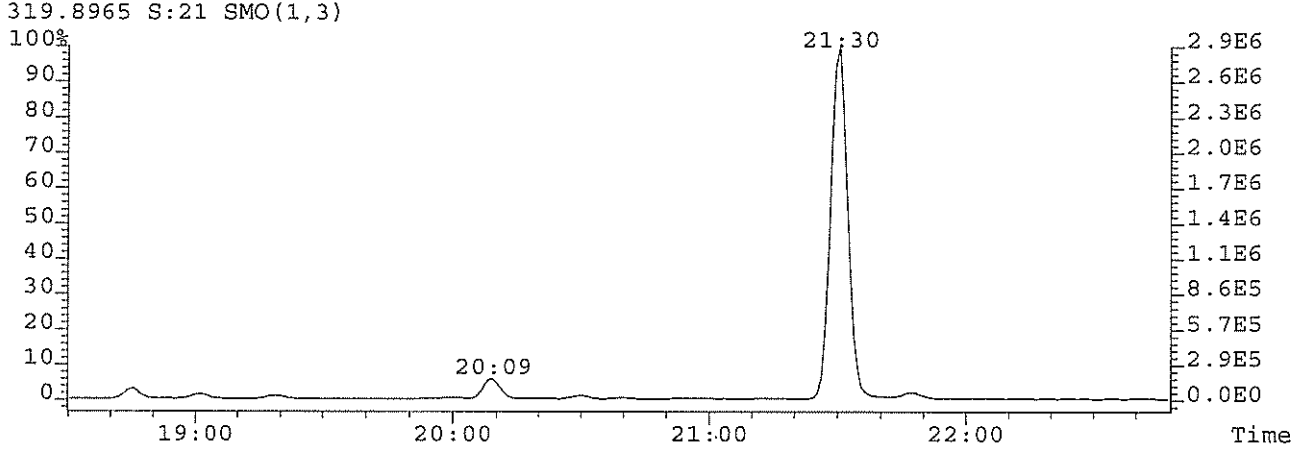


317.9389 S:21 SMO(1,3)



PCDFsクロマトグラム (1)  
(TeCDFs)

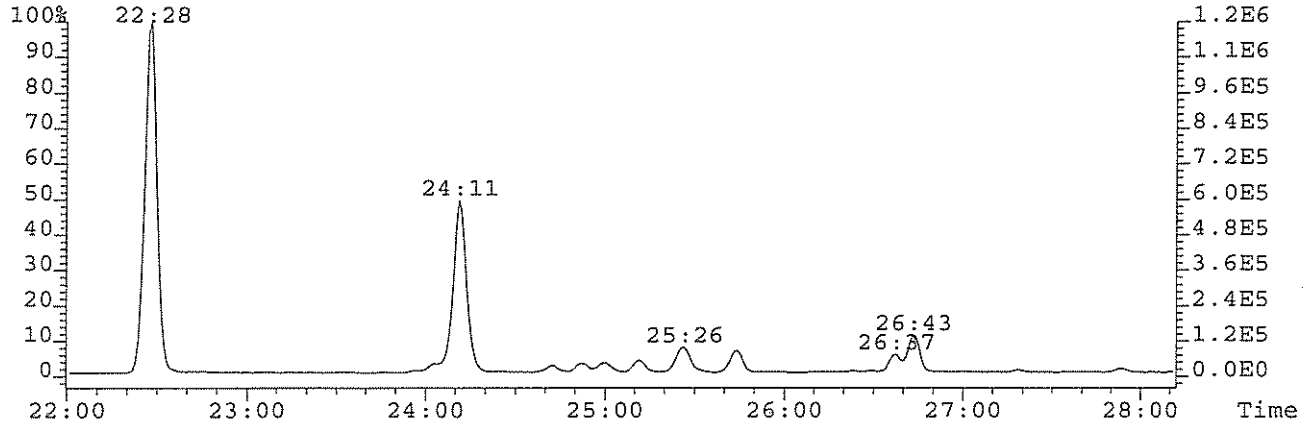
File:130710-2 #1-1578 Acq:11-JUL-2013 07:16:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:BPX-DXN(4-6DXN) Text:XE13 0951 Exp:BPX04



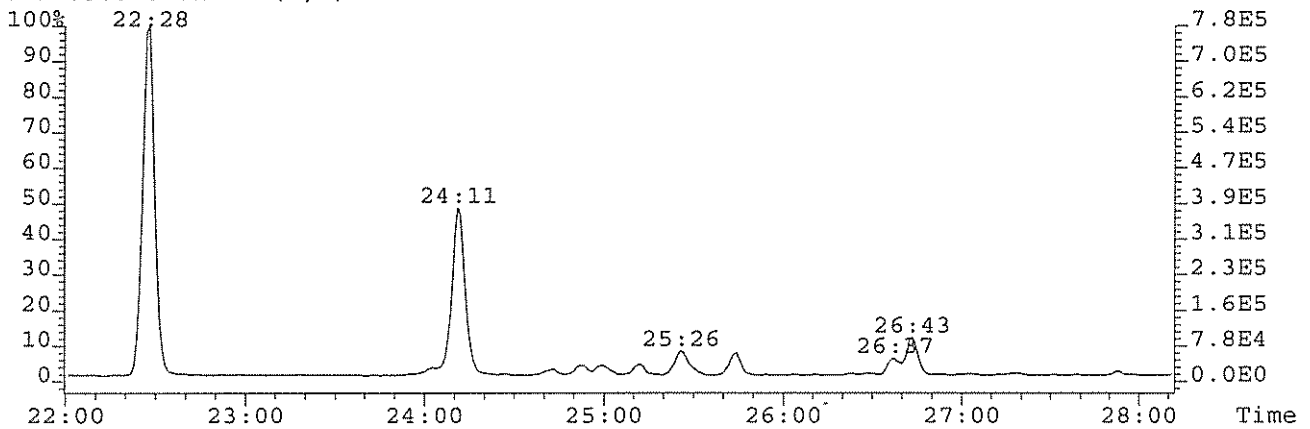
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130710-2 #1-1578 Acq:11-JUL-2013 07:16:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:BPX-DXN(4-6DXN) Text:XE13 0951 Exp:BPX04

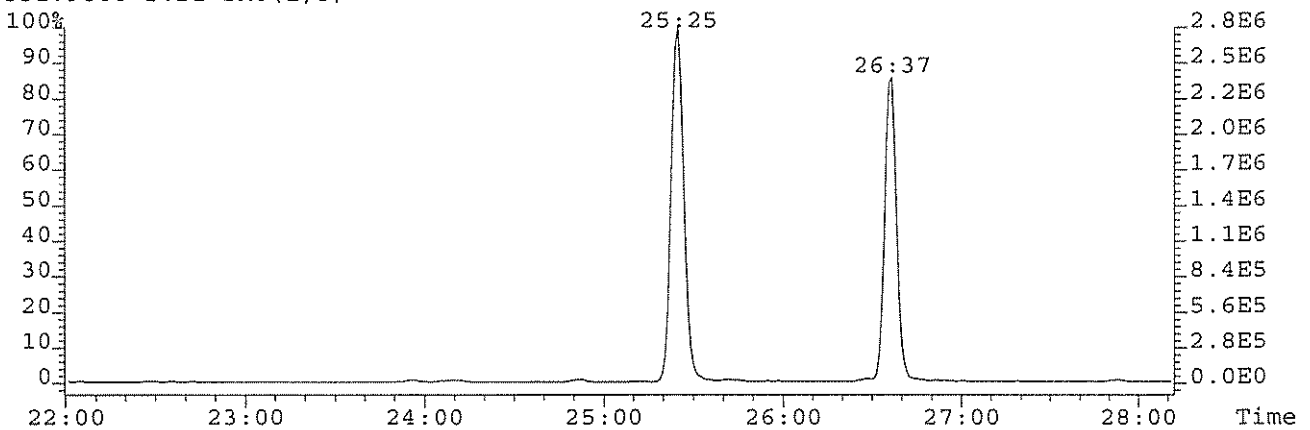
339.8597 S:21 SMO(1,3)



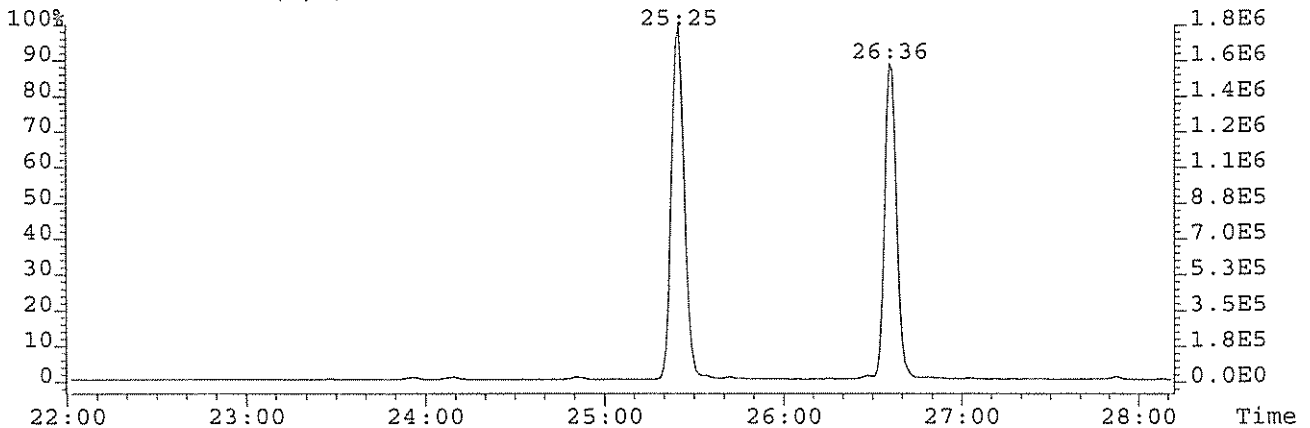
341.8568 S:21 SMO(1,3)



351.9000 S:21 SMO(1,3)

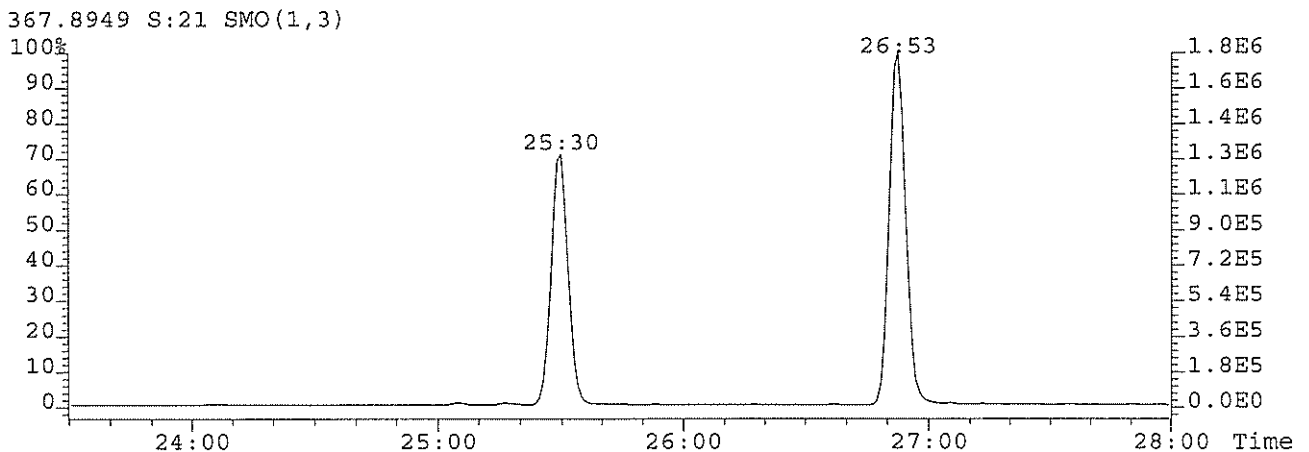
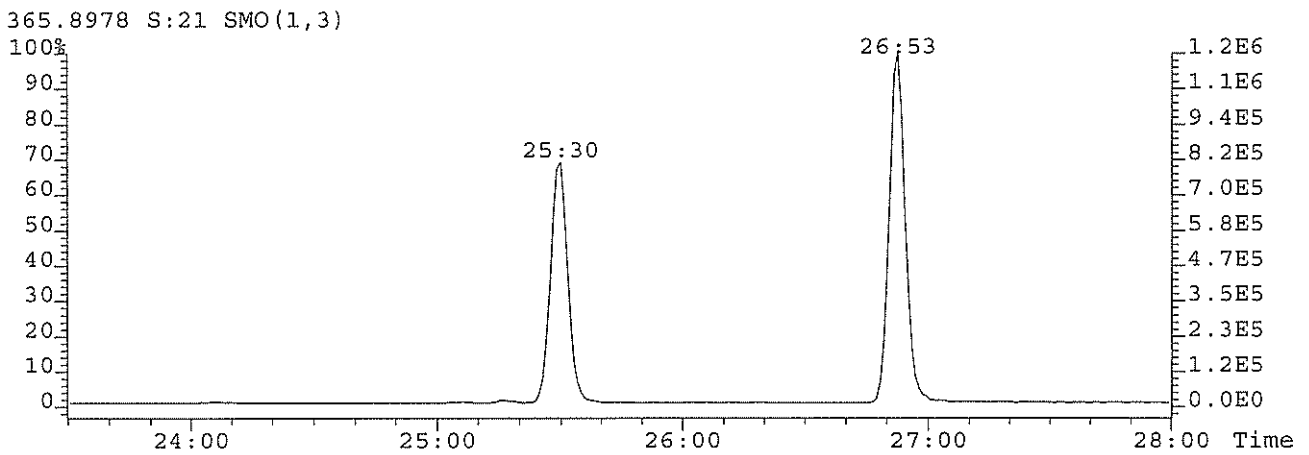
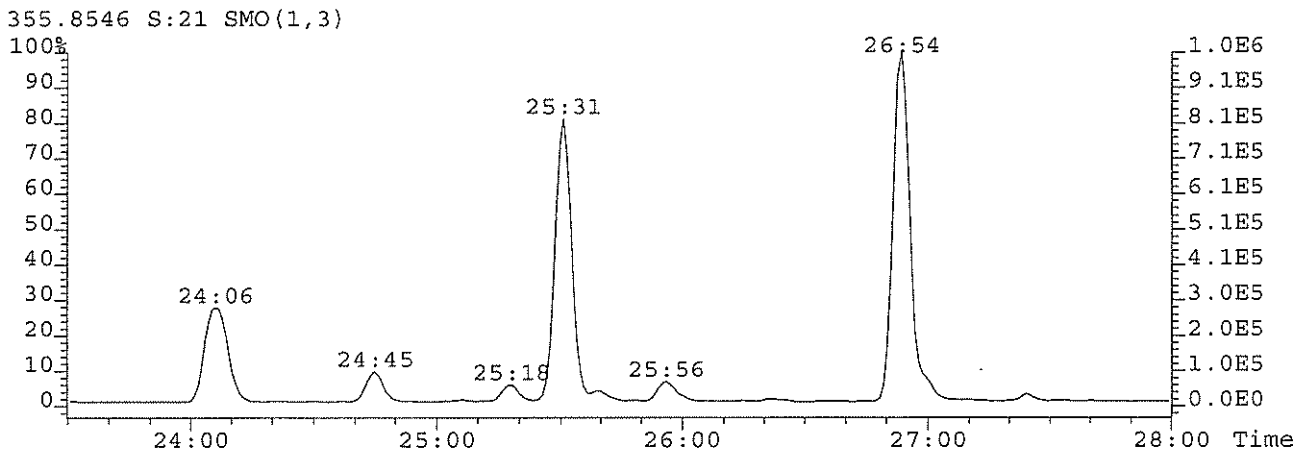
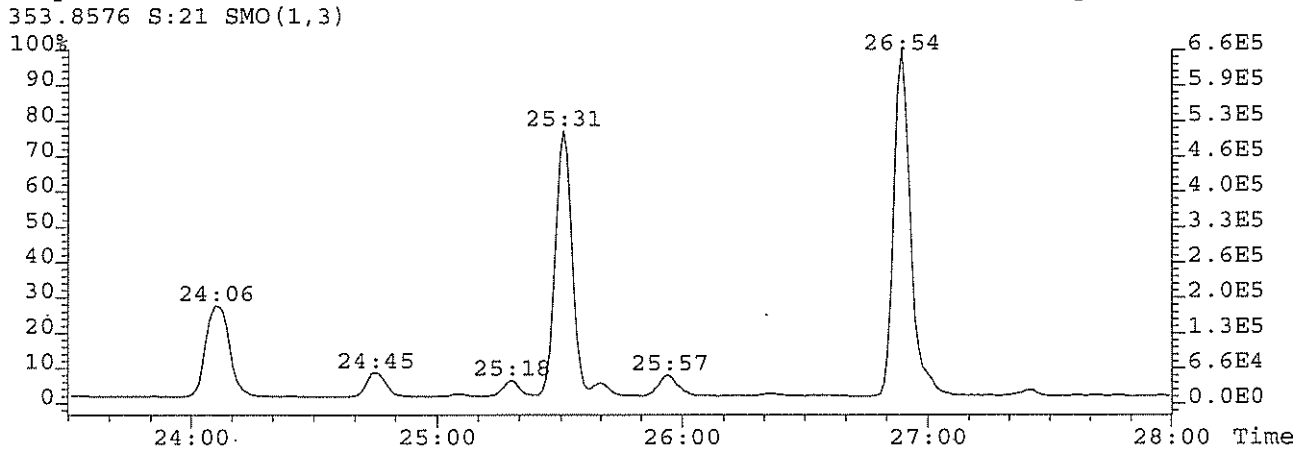


353.8970 S:21 SMO(1,3)



PCDFsクロマトグラム (3)  
(PeCDFs)

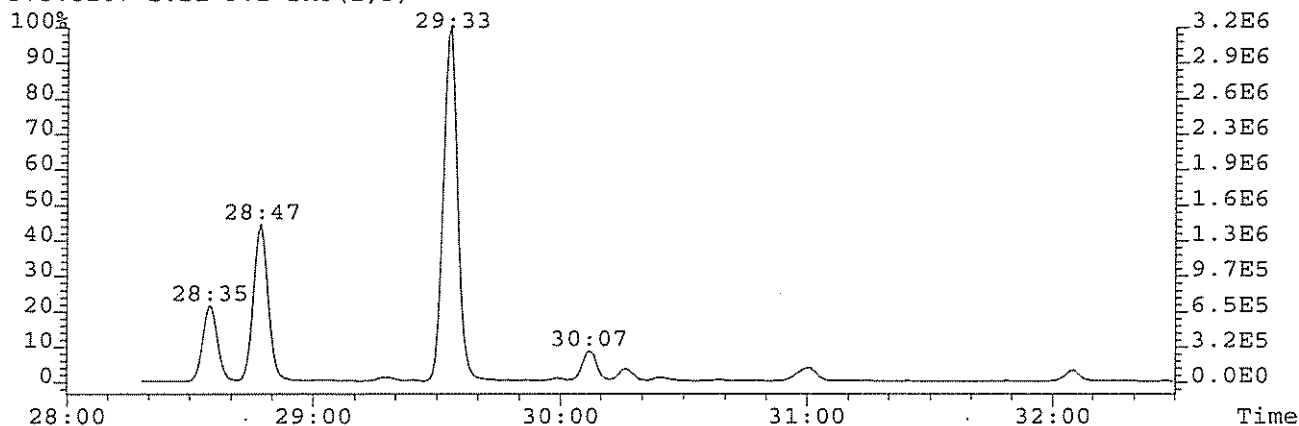
File:130710-2 #1-1578 Acq:11-JUL-2013 07:16:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:BPX-DXN(4-6DXN) Text:XE13 0951 Exp:BPX04



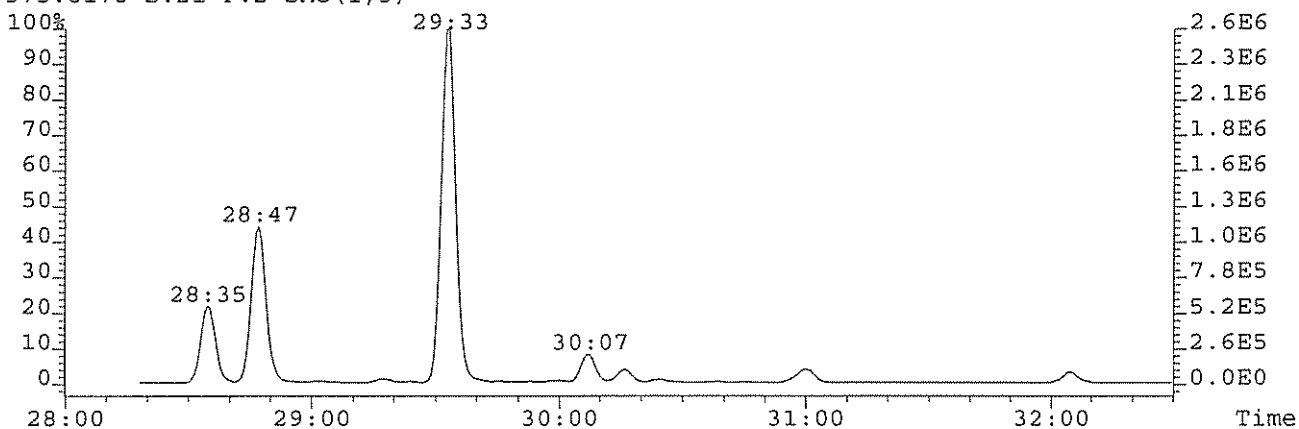
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130710-2 #1-1116 Acq:11-JUL-2013 07:16:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:BPX-DXN(4-6DXN) Text:XE13 0951 Exp:BPX04

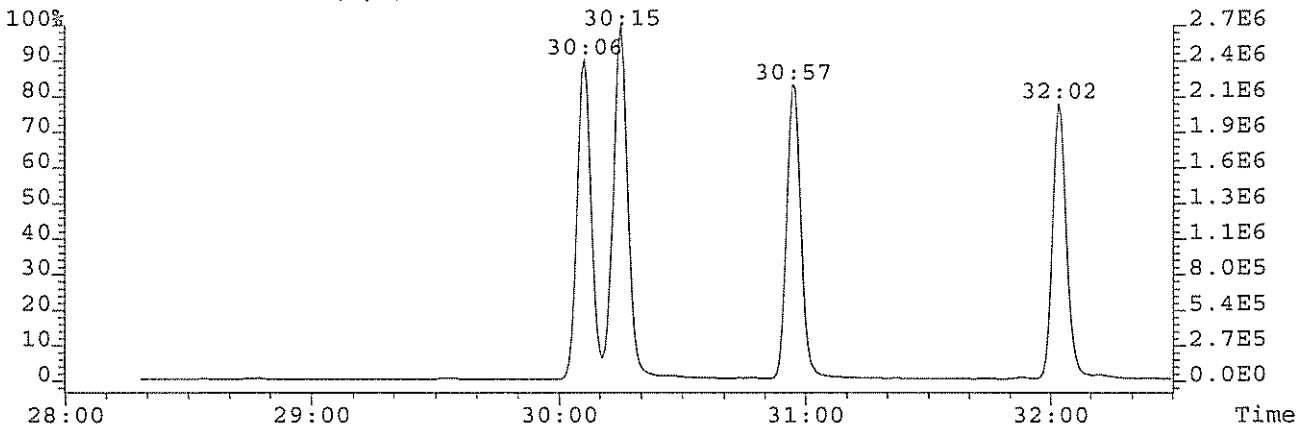
373.8207 S:21 F:2 SMO(1,3)



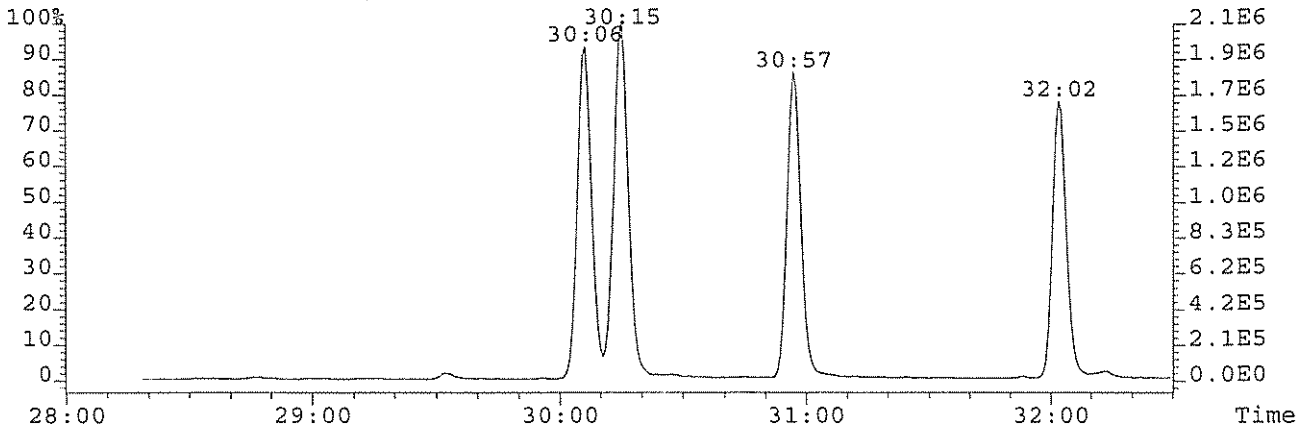
375.8178 S:21 F:2 SMO(1,3)



385.8610 S:21 F:2 SMO(1,3)



387.8580 S:21 F:2 SMO(1,3)

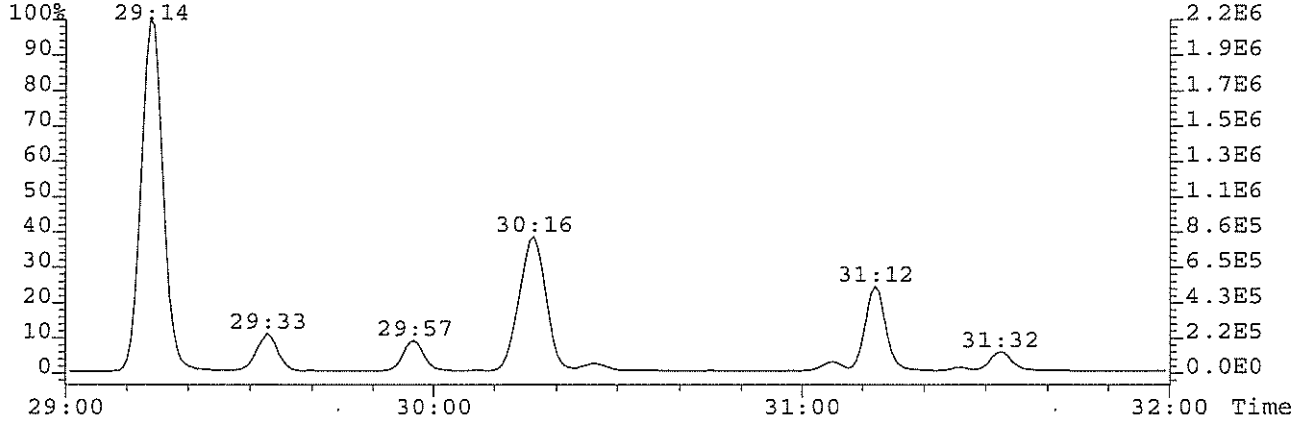


PCDFsクロマトグラム (5)  
(HxCDFs)

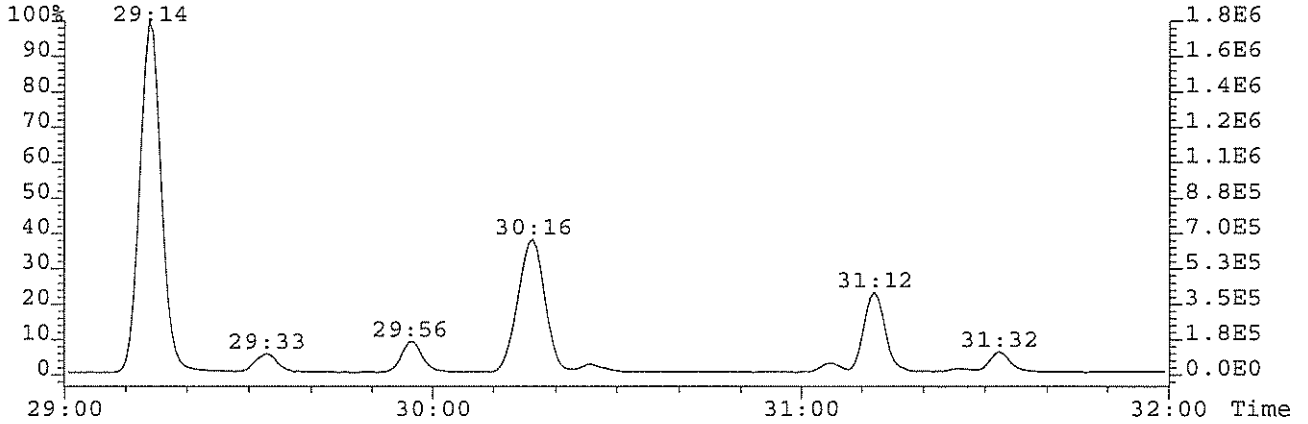


File:130710-2 #1-1116 Acq:11-JUL-2013 07:16:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:BPX-DXN(4-6DXN) Text:XE13 0951 Exp:BPX04

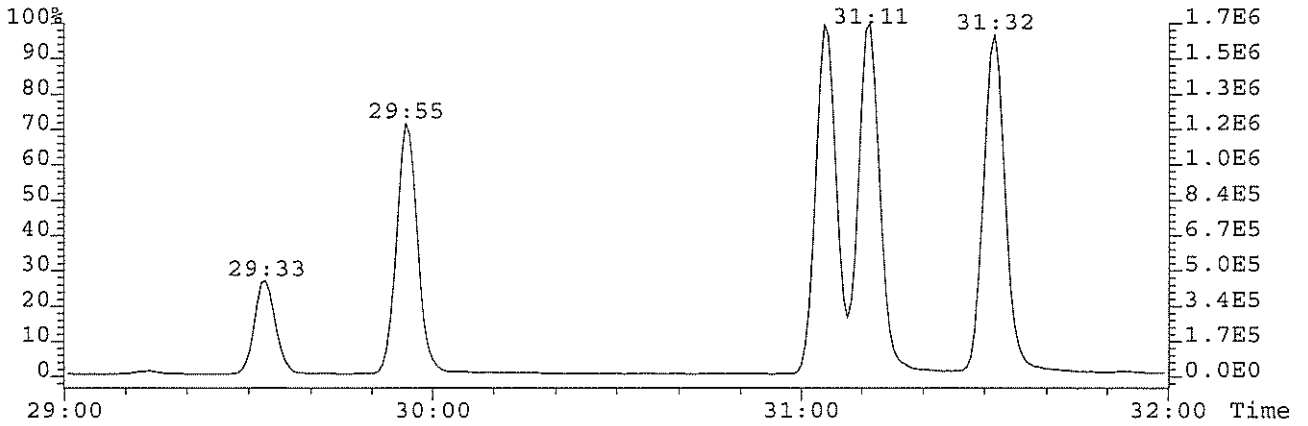
389.8156 S:21 F:2 SMO(1,3)



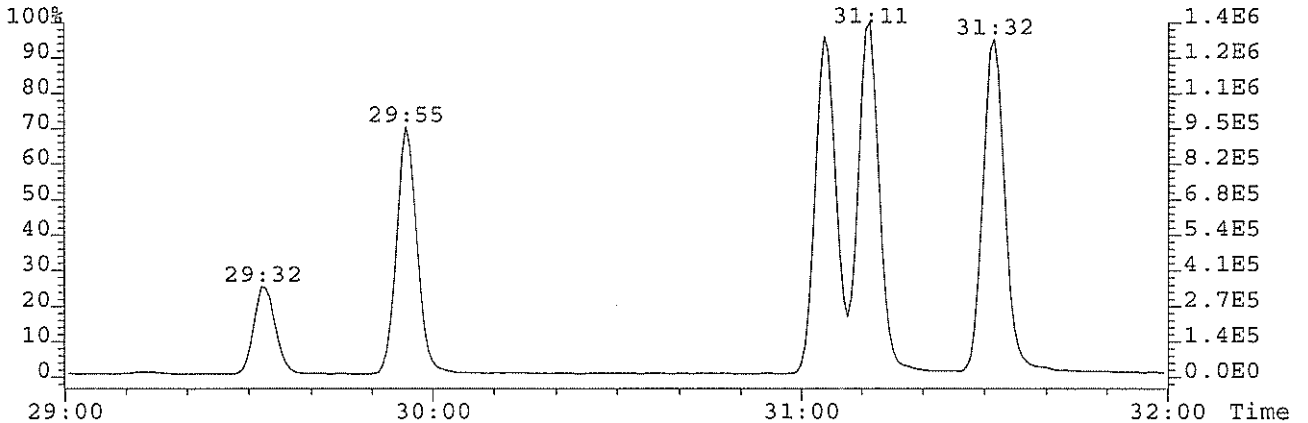
391.8127 S:21 F:2 SMO(1,3)



401.8559 S:21 F:2 SMO(1,3)

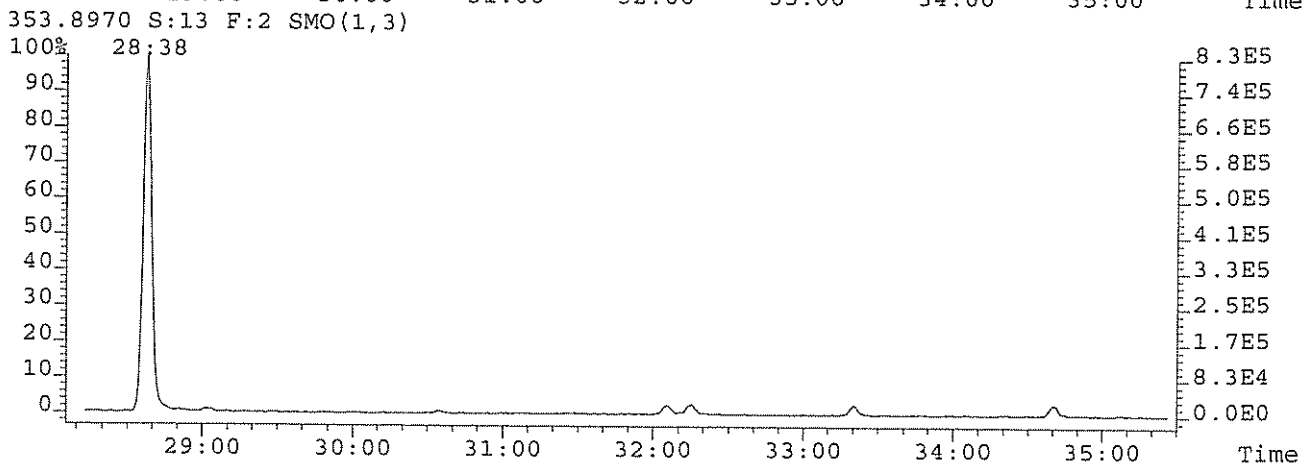
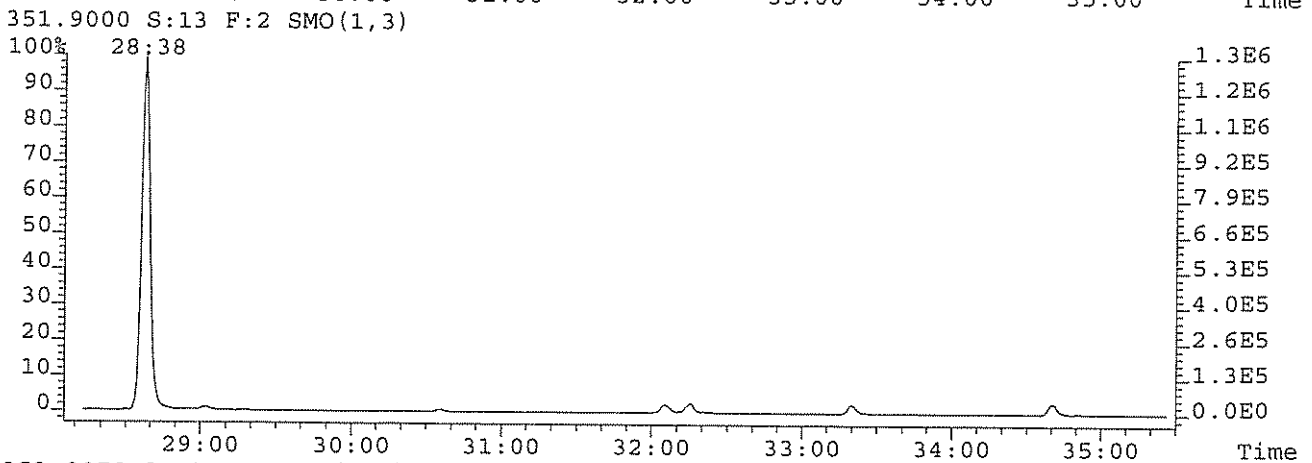
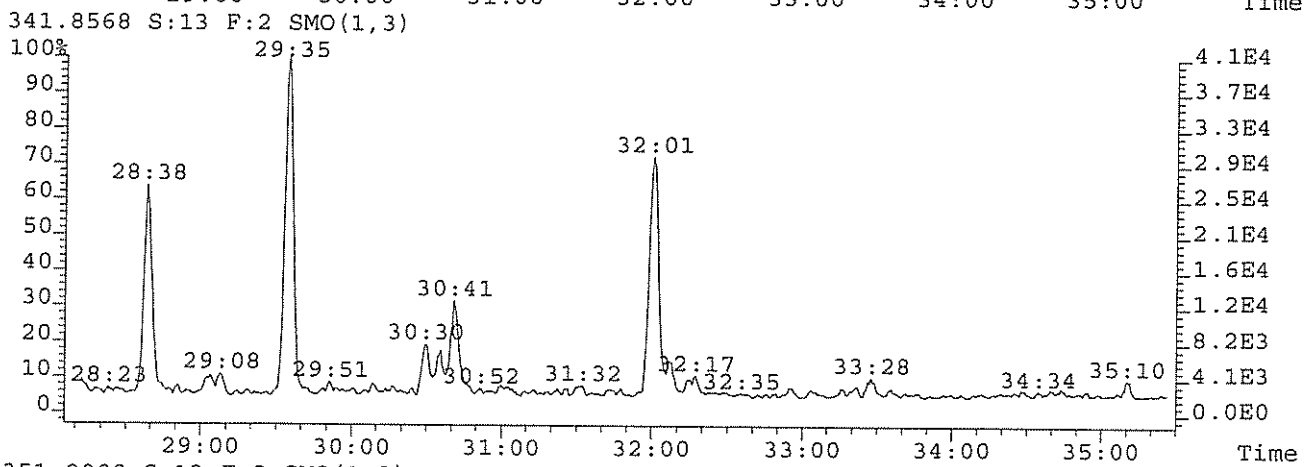
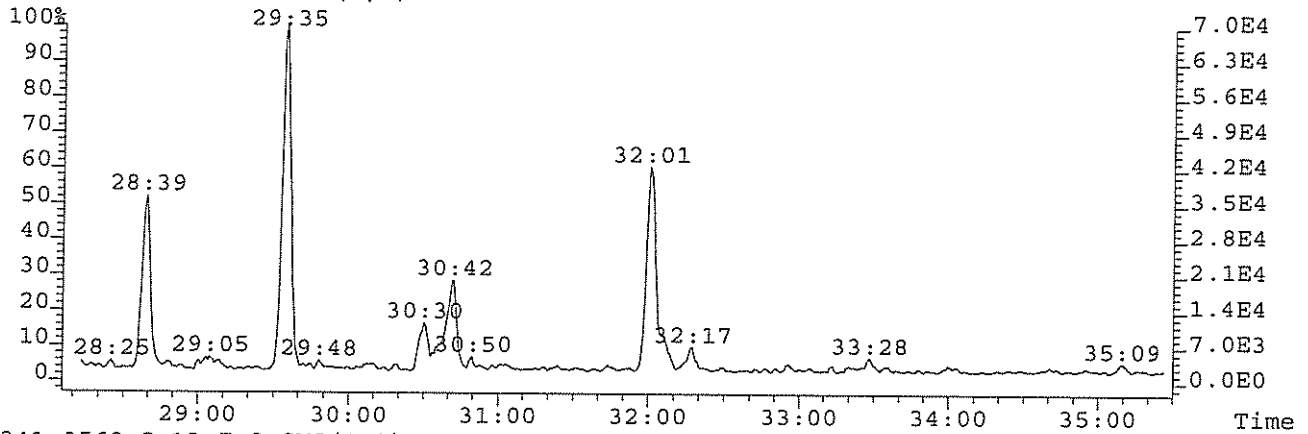


403.8530 S:21 F:2 SMO(1,3)



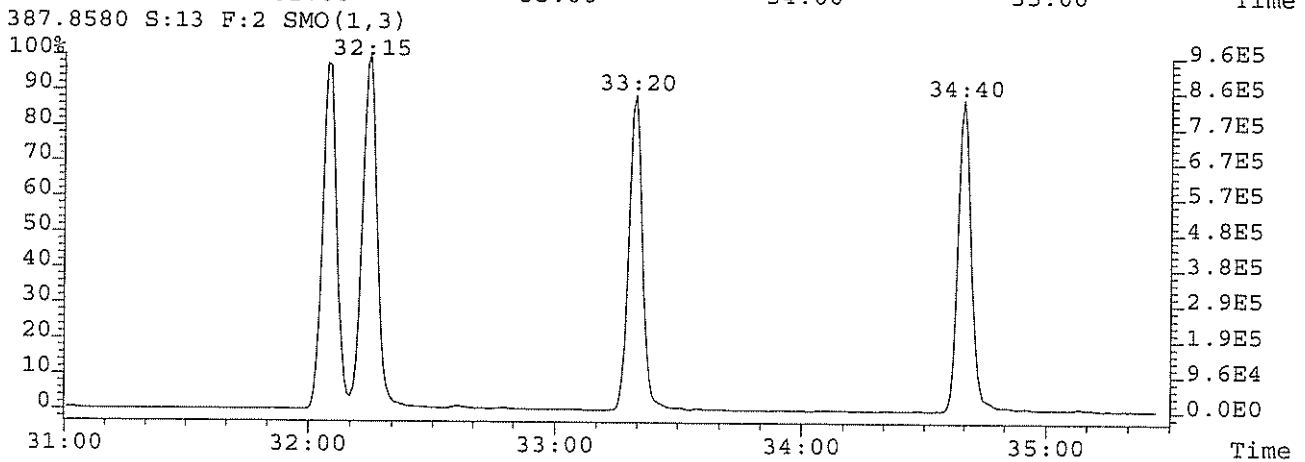
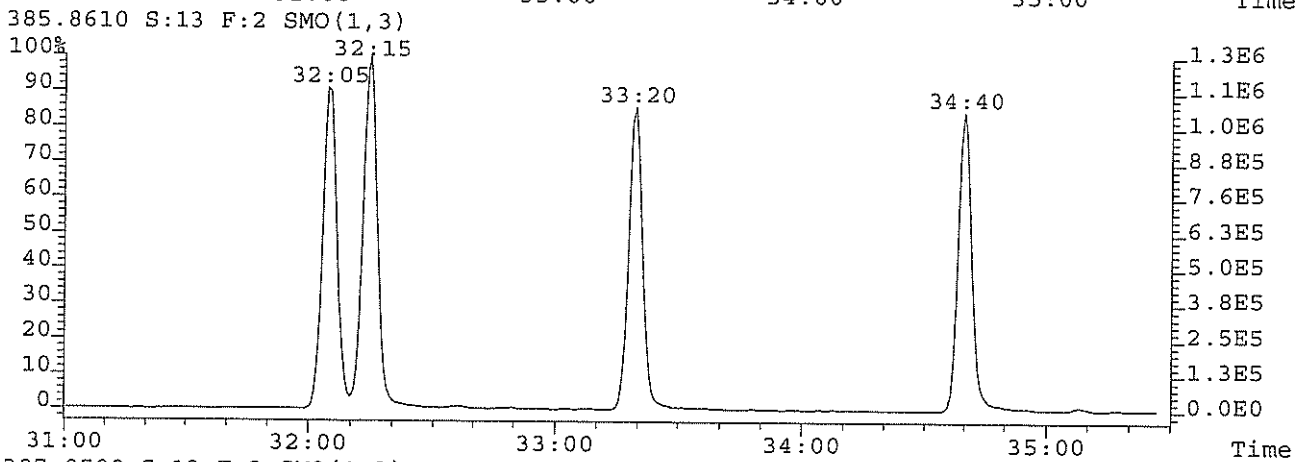
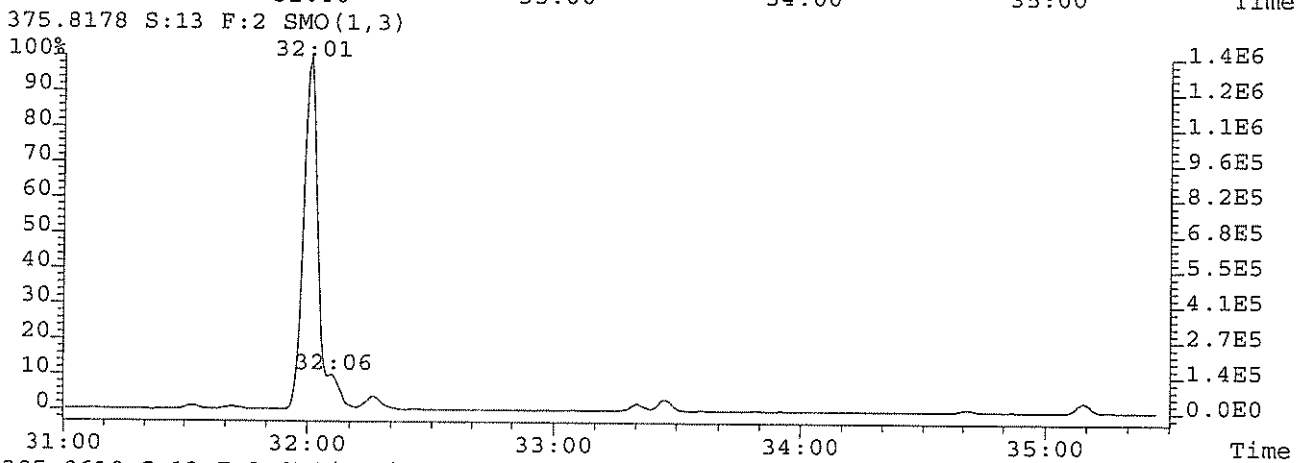
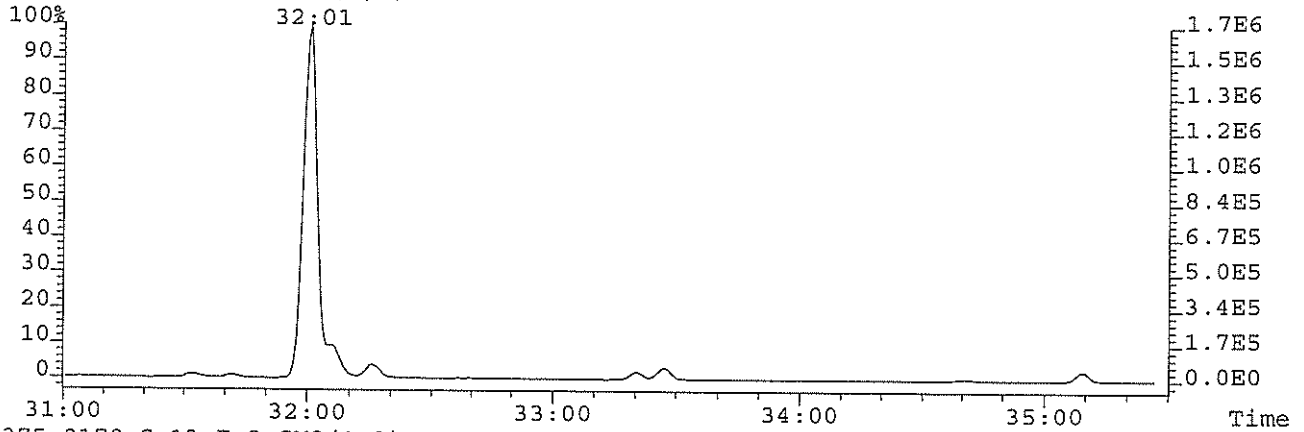
PCDDsクロマトグラム (6)  
(HxCDDs)

File:130711-2 #1-649 Acq:12-JUL-2013 04:47:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:RH-12ms(5-8,nP) Text:XE13 0951 3 Exp:RH-PD22  
339.8597 S:13 F:2 SMO(1,3)



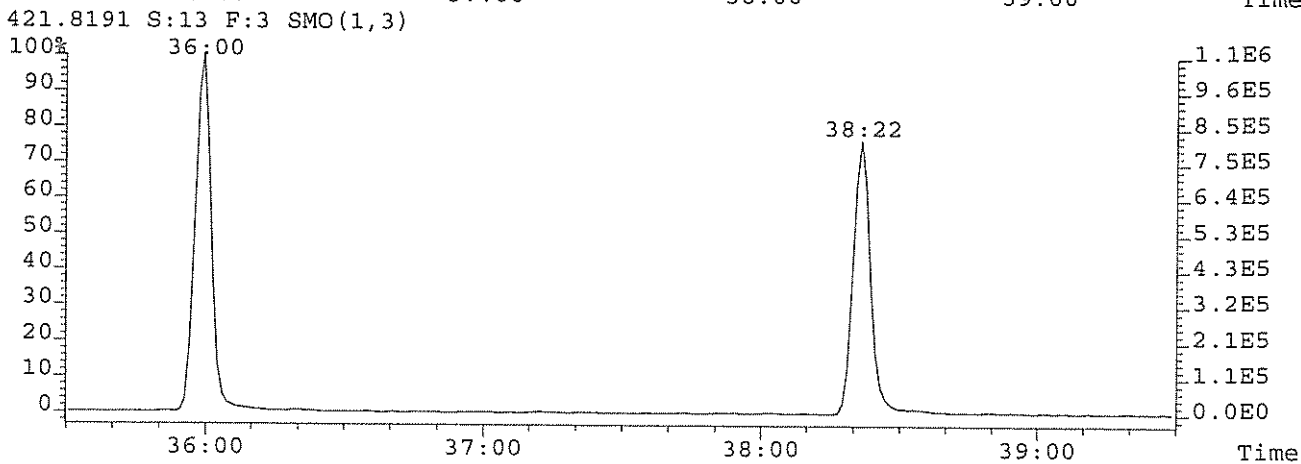
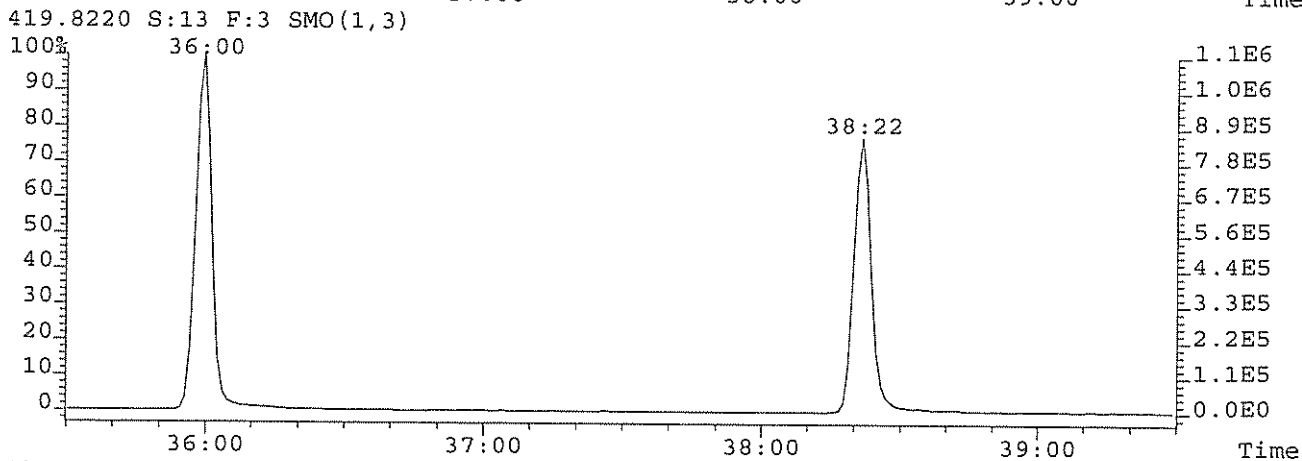
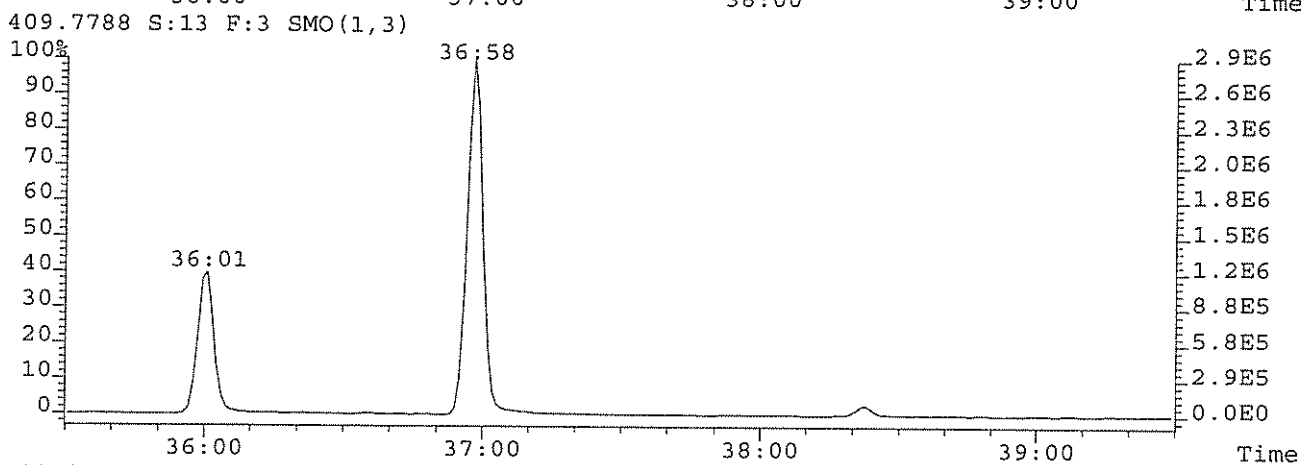
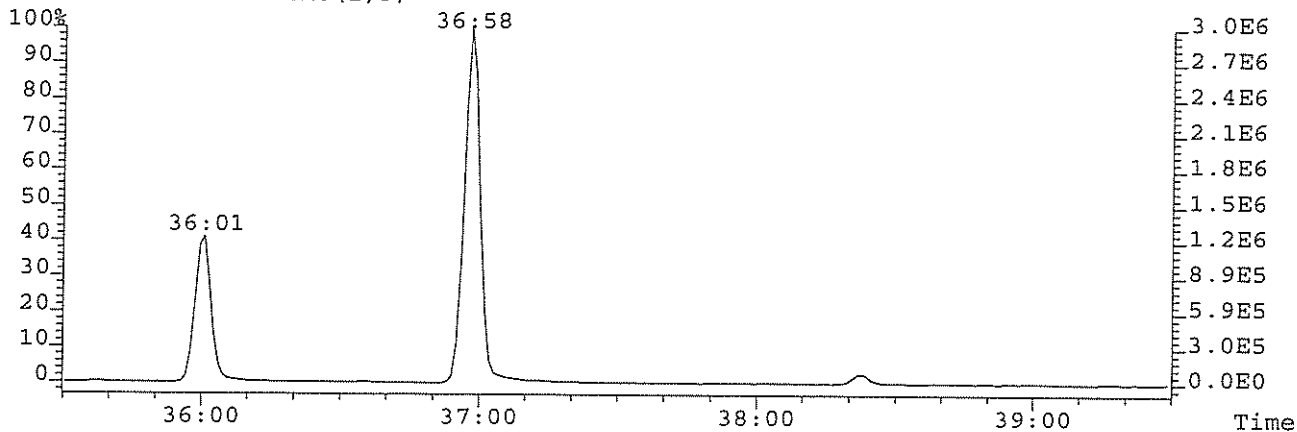
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130711-2 #1-649 Acq:12-JUL-2013 04:47:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:RH-12ms(5-8,nP) Text:XE13 0951 3 Exp:RH-PD22



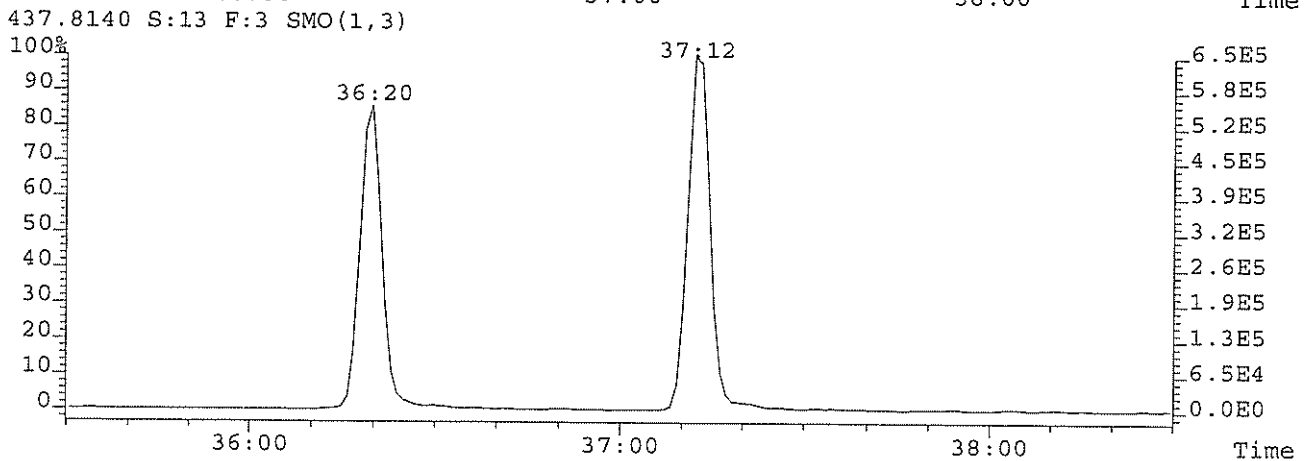
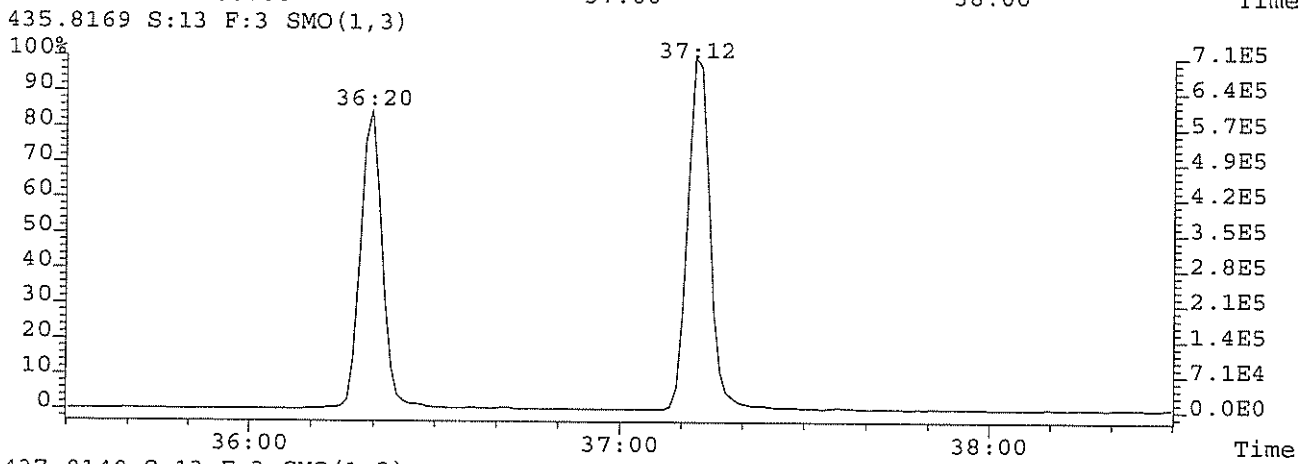
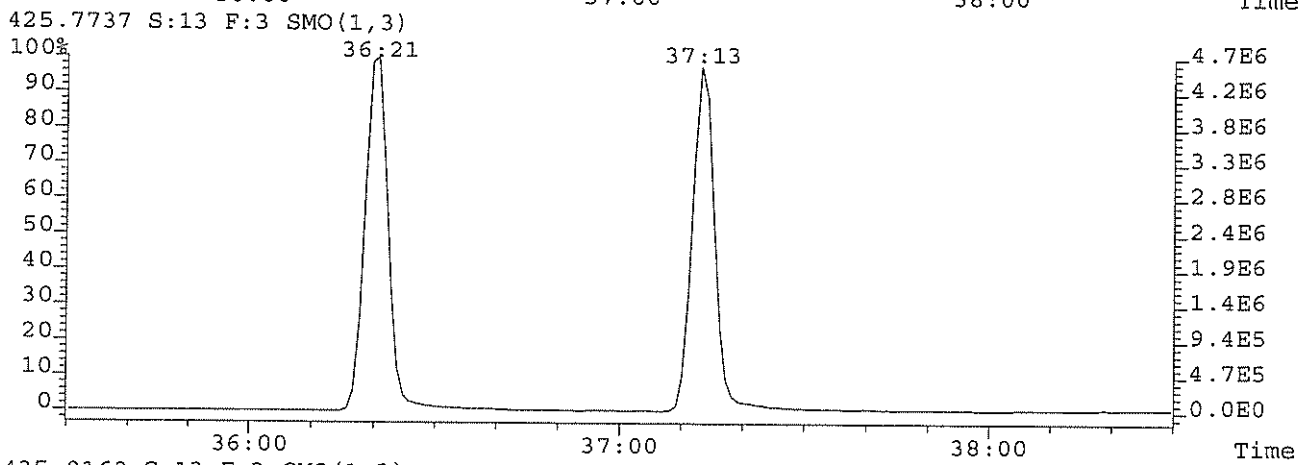
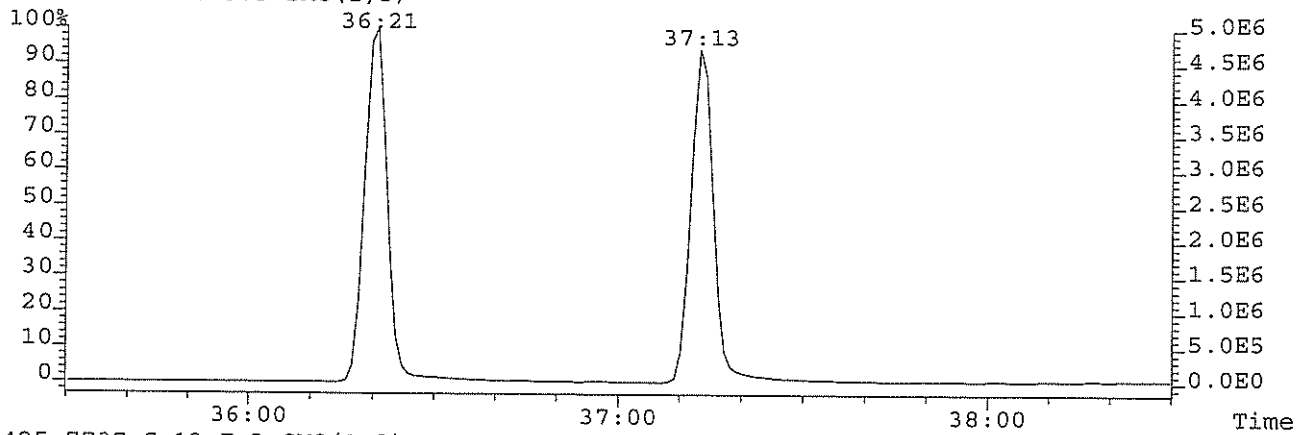
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130711-2 #1-562 Acq:12-JUL-2013 04:47:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:RH-12ms(5-8,nP) Text:XE13 0951 3 Exp:RH-PD22  
407.7818 S:13 F:3 SMO(1,3)



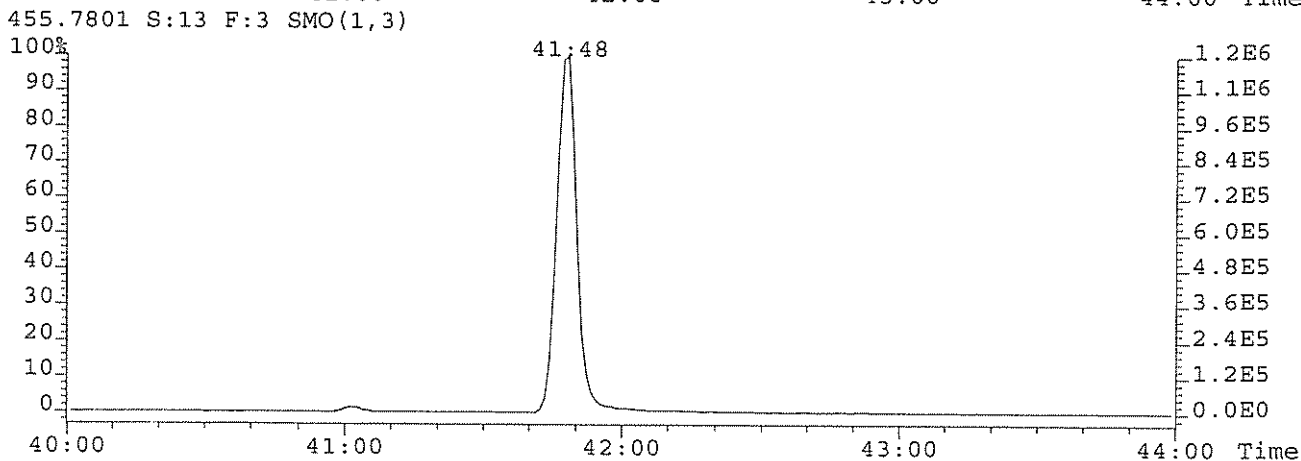
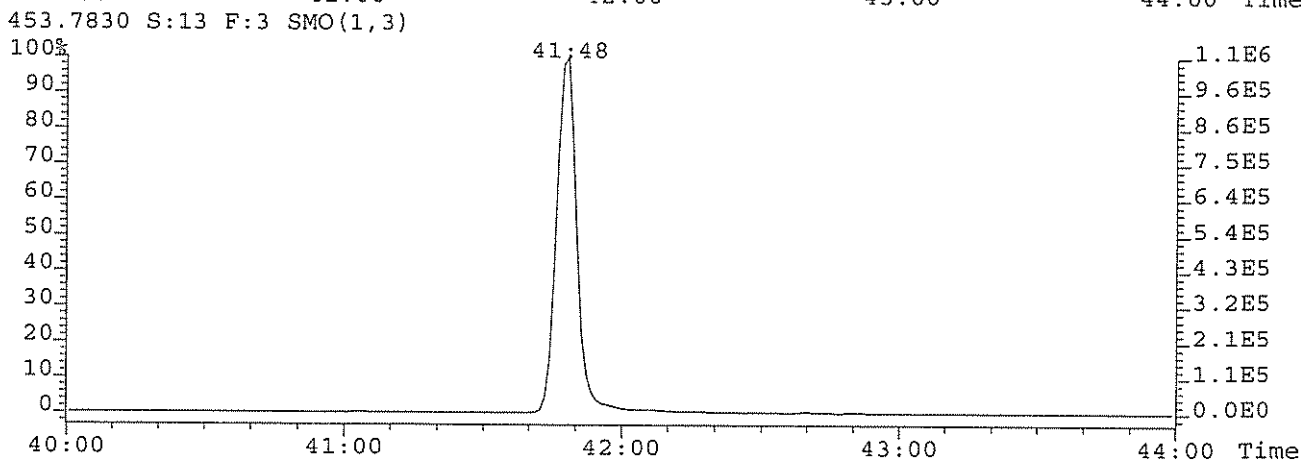
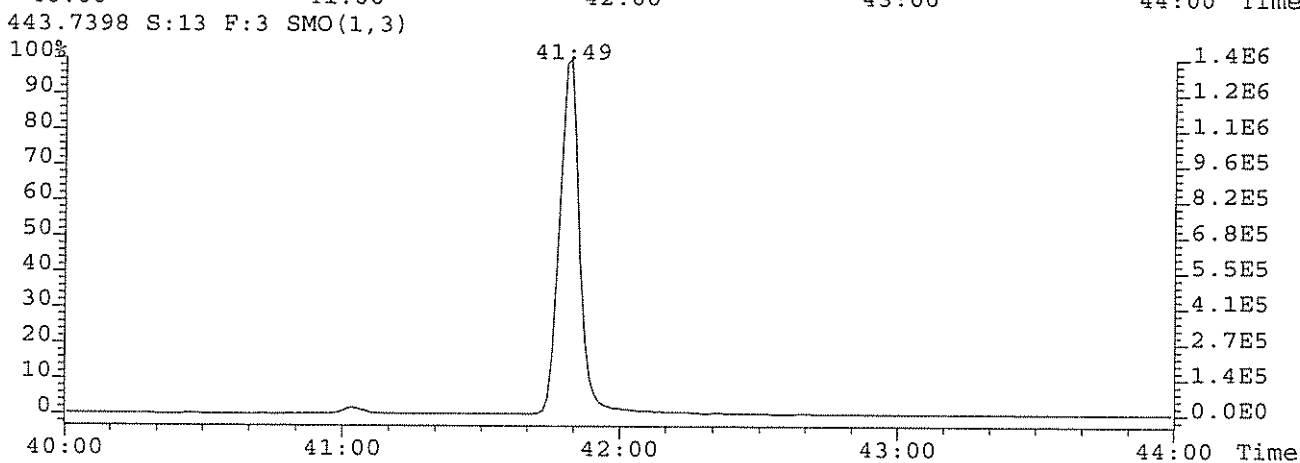
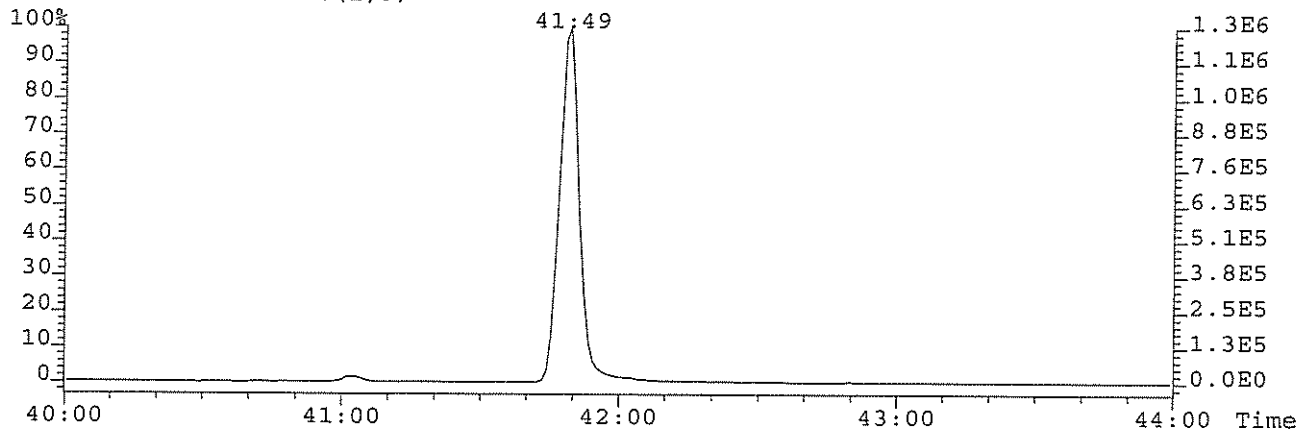
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130711-2 #1-562 Acq:12-JUL-2013 04:47:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:RH-12ms(5-8,nP) Text:XE13 0951 3 Exp:RH-PD22

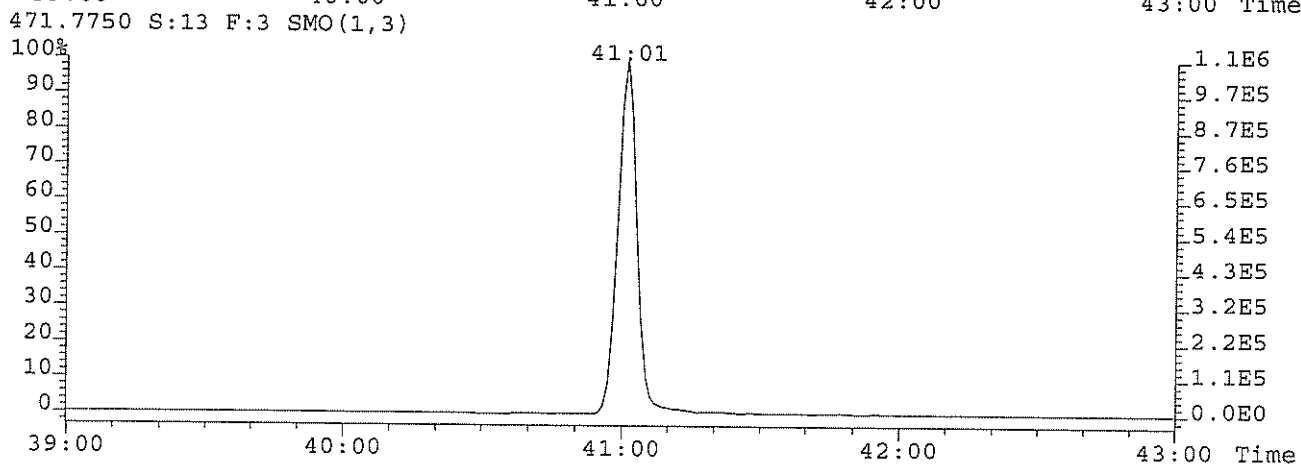
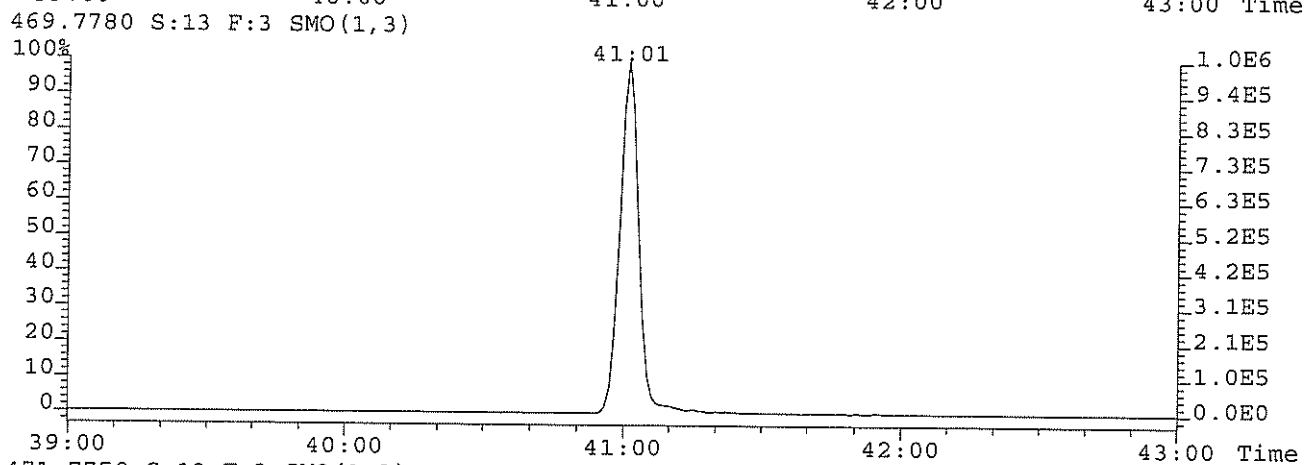
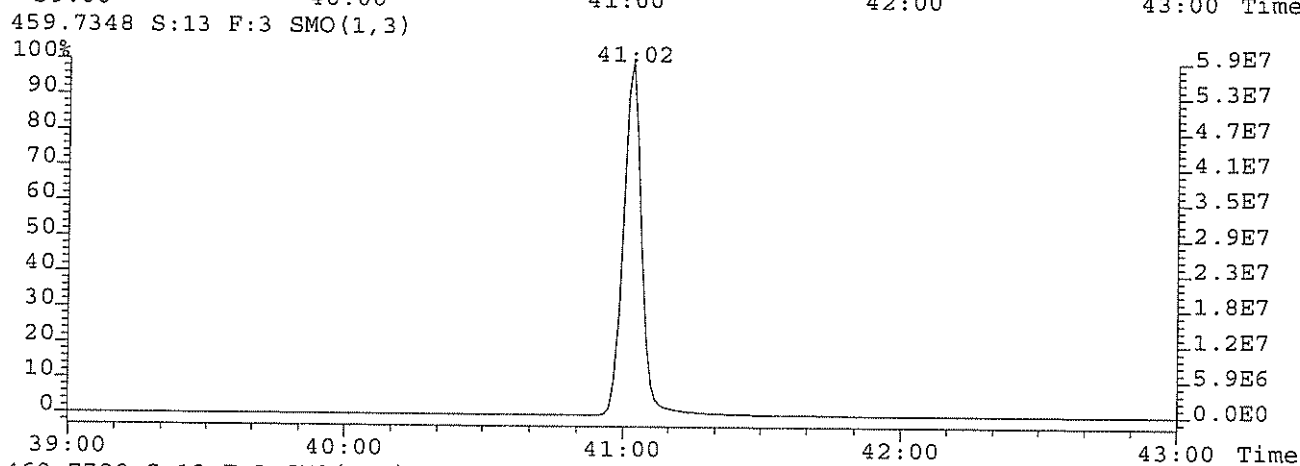
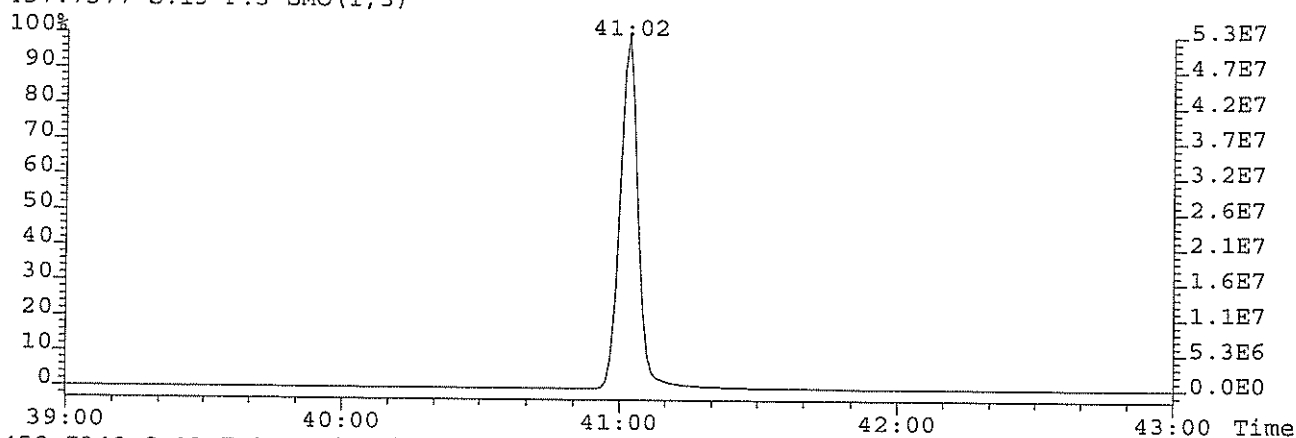


PCDDsクロマトグラム (10)  
(HpCDDs)

File:130711-2 #1-562 Acq:12-JUL-2013 04:47:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:RH-12ms(5-8,nP) Text:XE13 0951 3 Exp:RH-PD22  
441.7428 S:13 F:3 SMO(1,3)

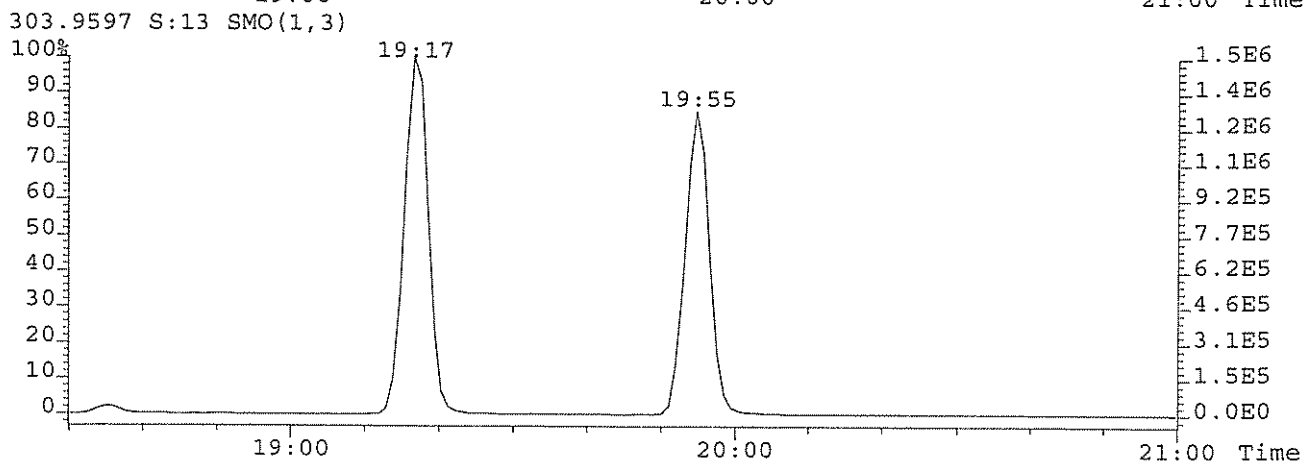
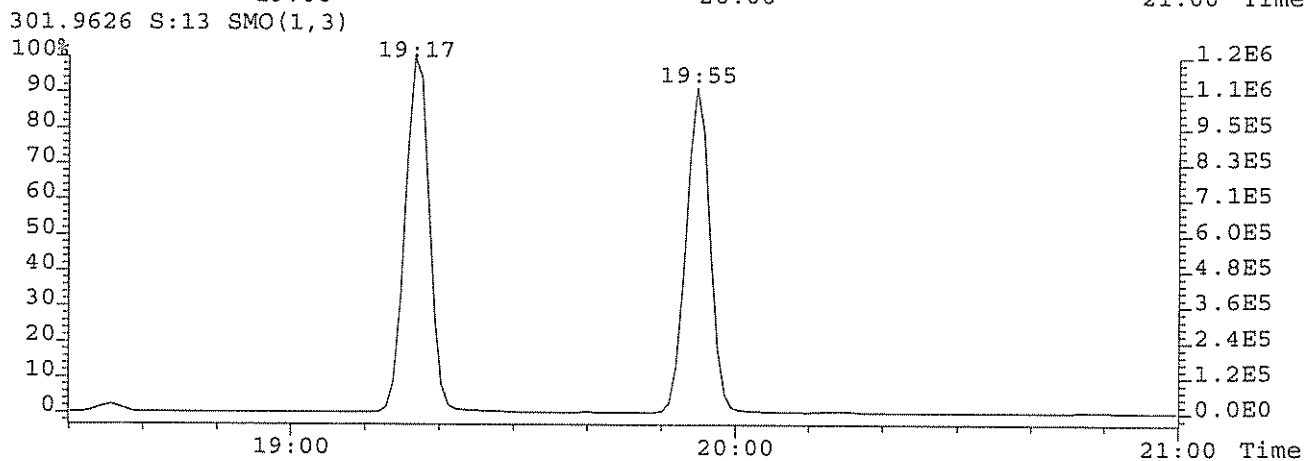
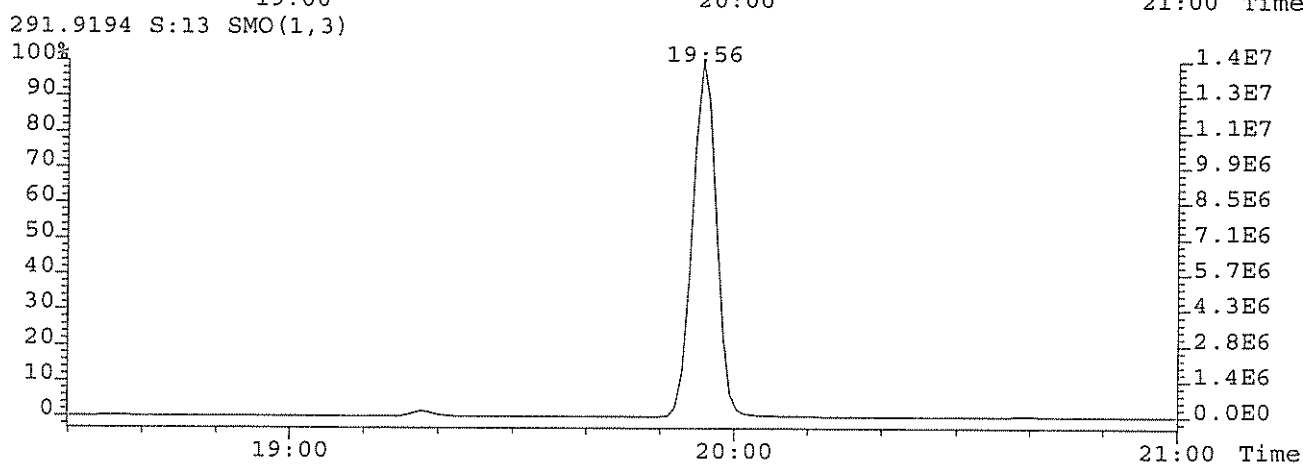
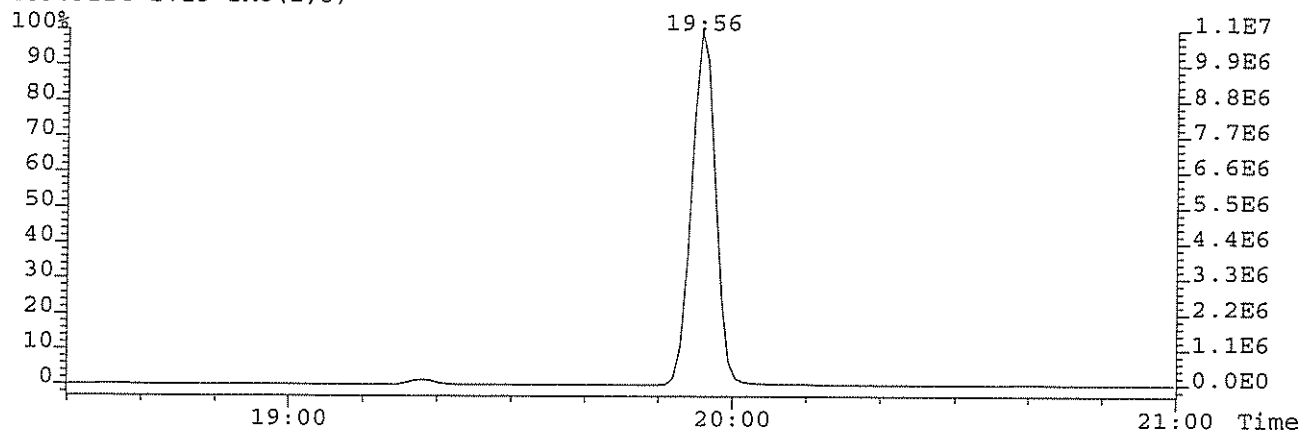


File:130711-2 #1-562 Acq:12-JUL-2013 04:47:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:RH-12ms(5-8,nP) Text:XE13 0951 3 Exp:RH-PD22



PCDDsクロマトグラム (12)  
(OCDD)

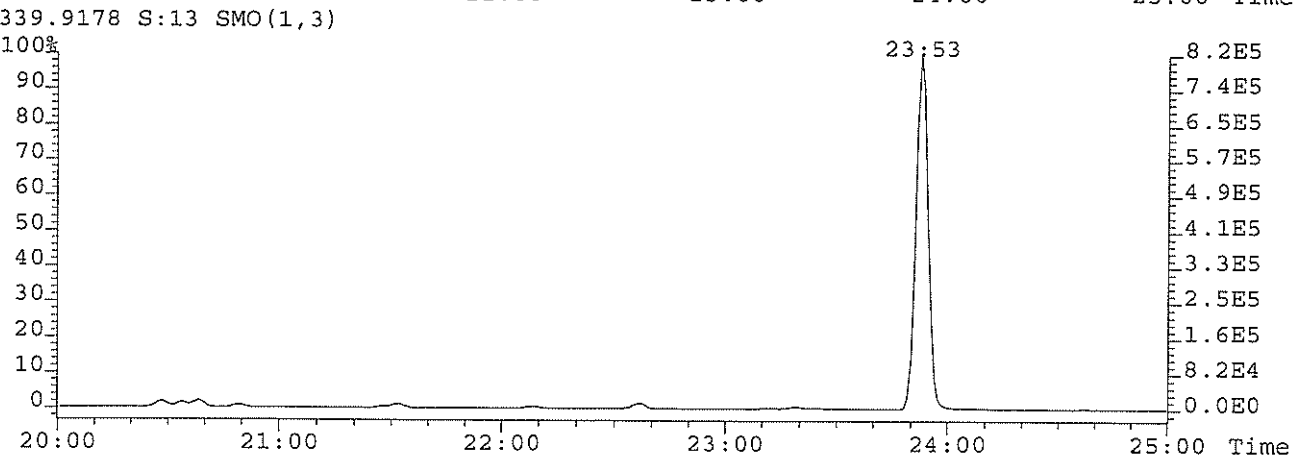
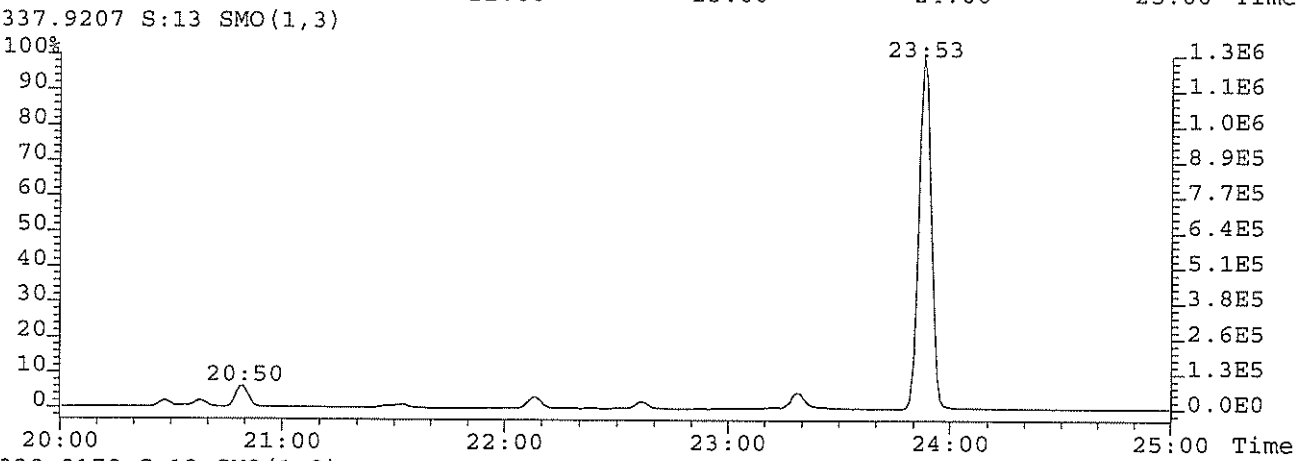
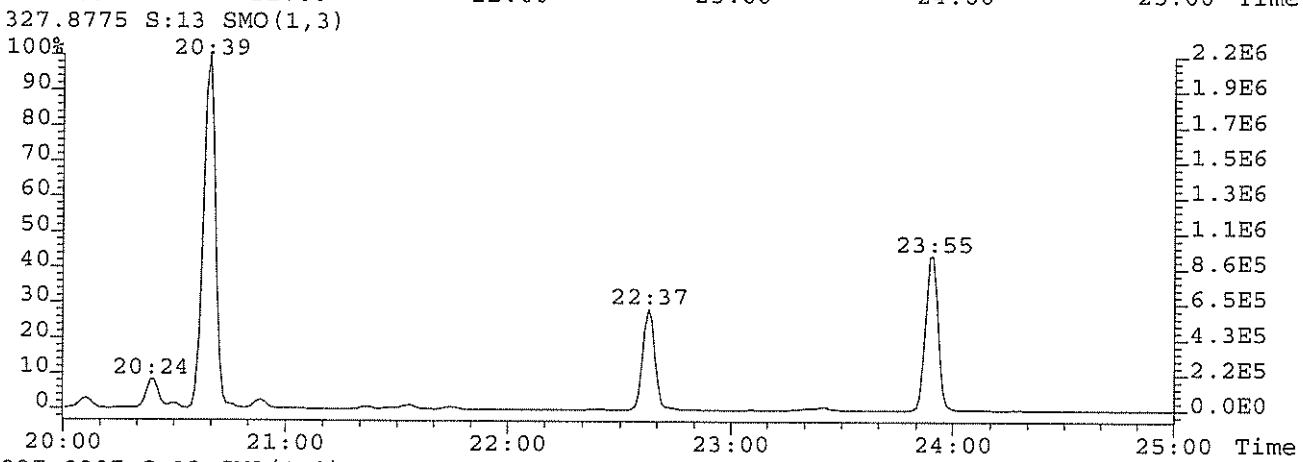
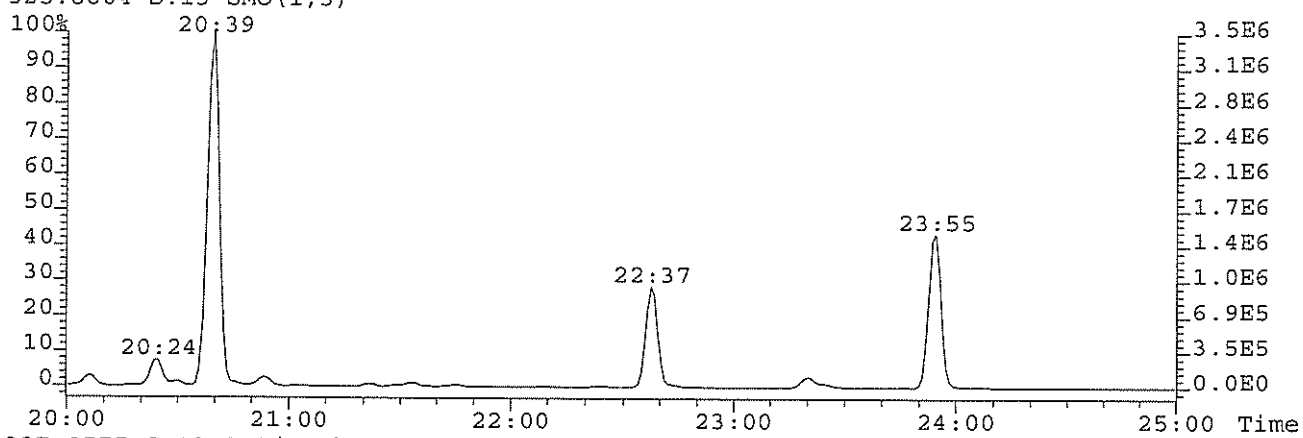
File:130711-2 #1-1430 Acq:12-JUL-2013 04:47:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:RH-12ms(5-8,nP) Text:XE13 0951 3 Exp:RH-PD22  
289.9224 S:13 SMO(1,3)



DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

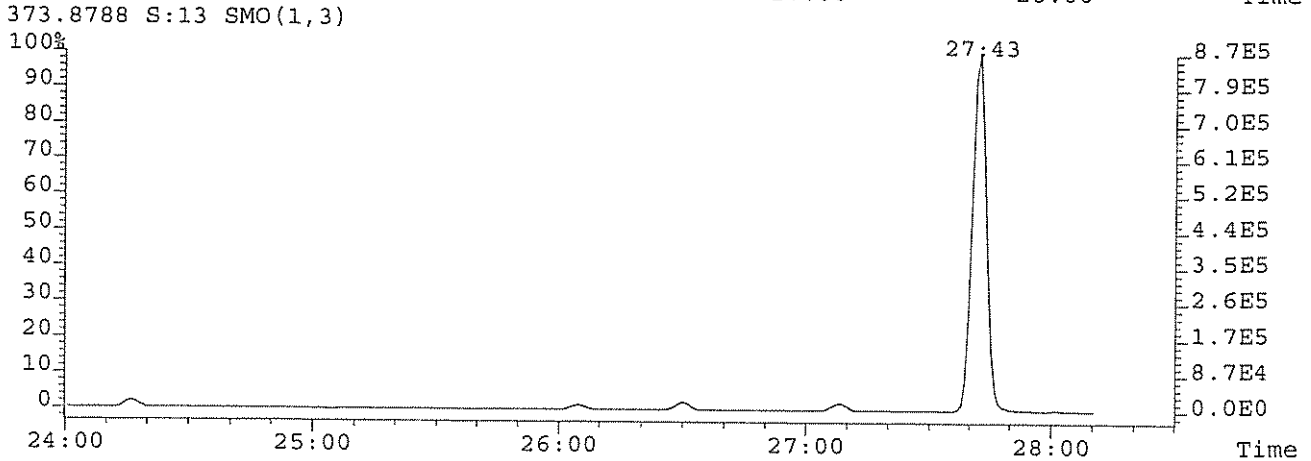
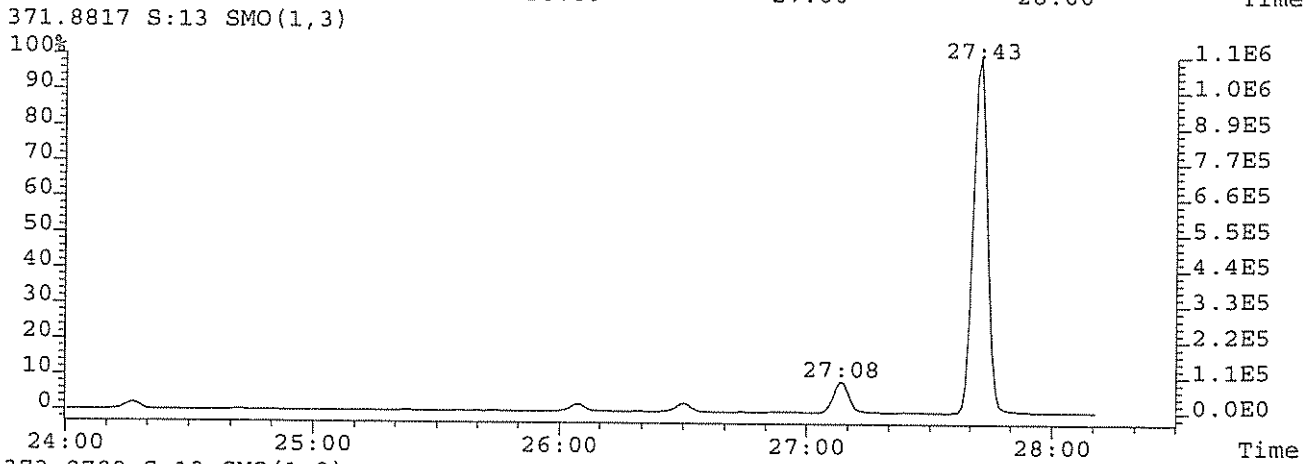
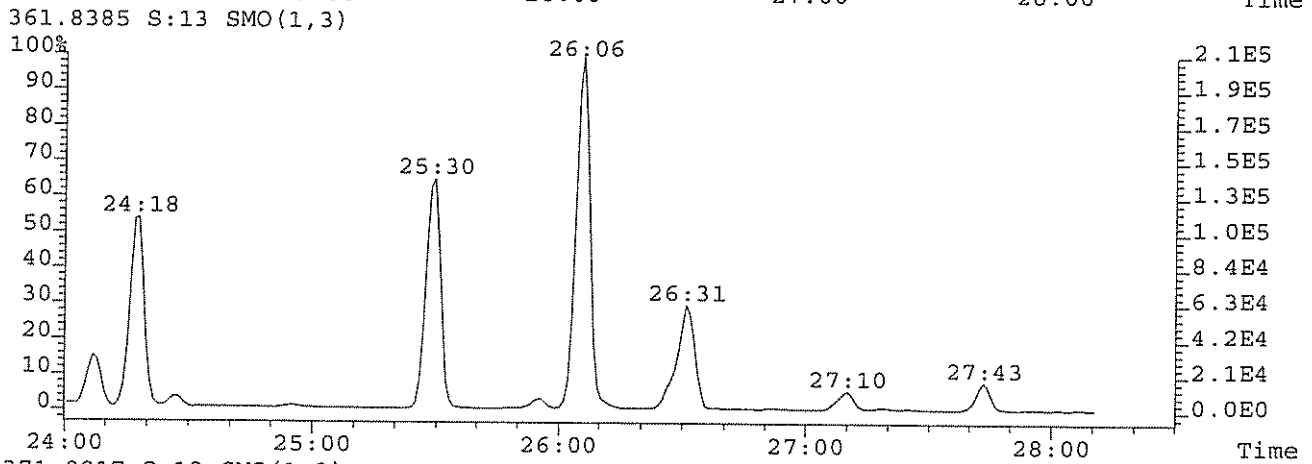
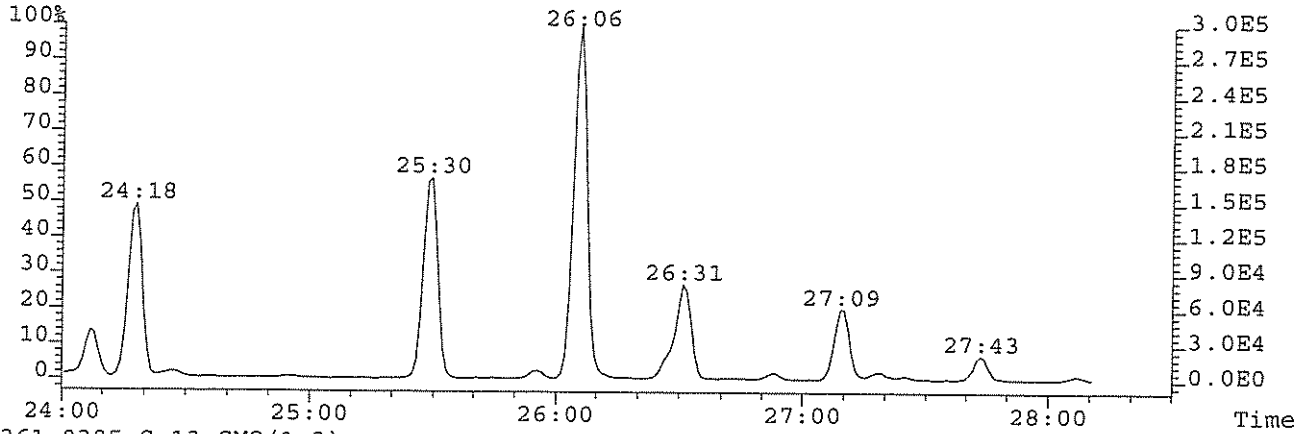


File:130711-2 #1-1430 Acq:12-JUL-2013 04:47:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:RH-12ms(5-8,nP) Text:XE13 0951 3 Exp:RH-PD22  
325.8804 S:13 SMO(1,3)



DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

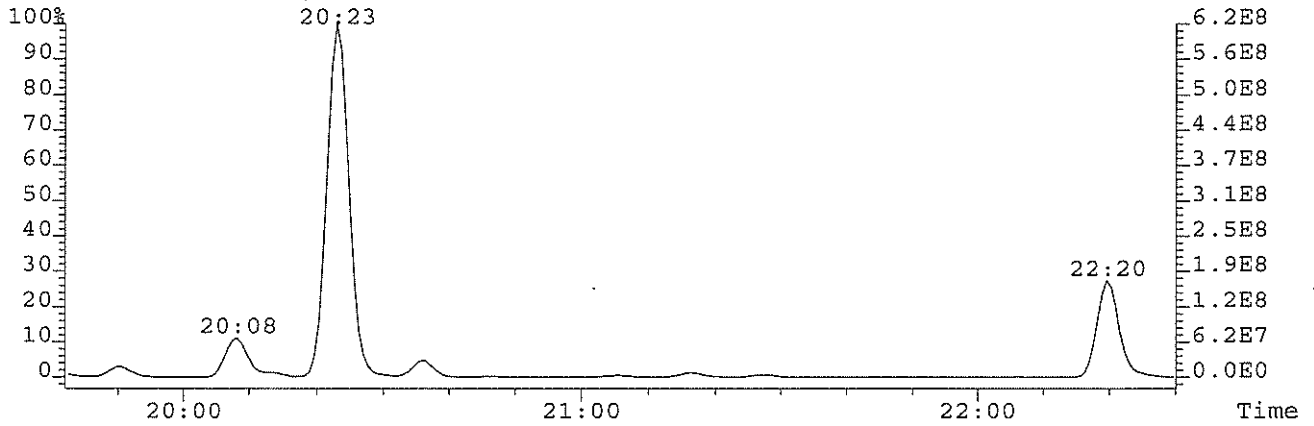
File:130711-2 #1-1430 Acq:12-JUL-2013 04:47:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:RH-12ms(5-8,nP) Text:XE13 0951 3 Exp:RH-PD22  
359.8415 S:13 SMO(1,3)



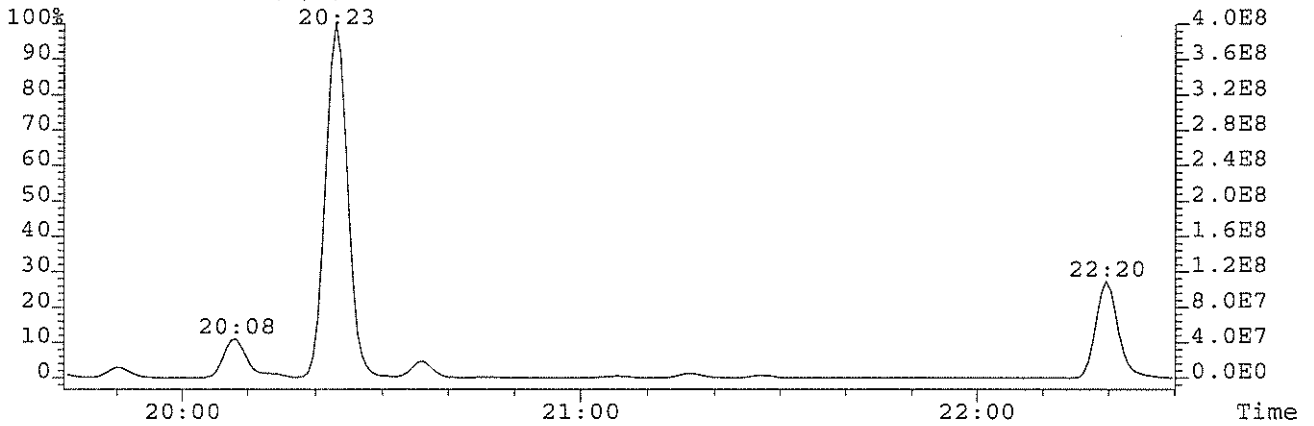
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130713 #1-2898 Acq:14-JUL-2013 03:27:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#23 File Text:RH-12ms(mP) Text:XE13 0951 2 Exp:RH-MP11

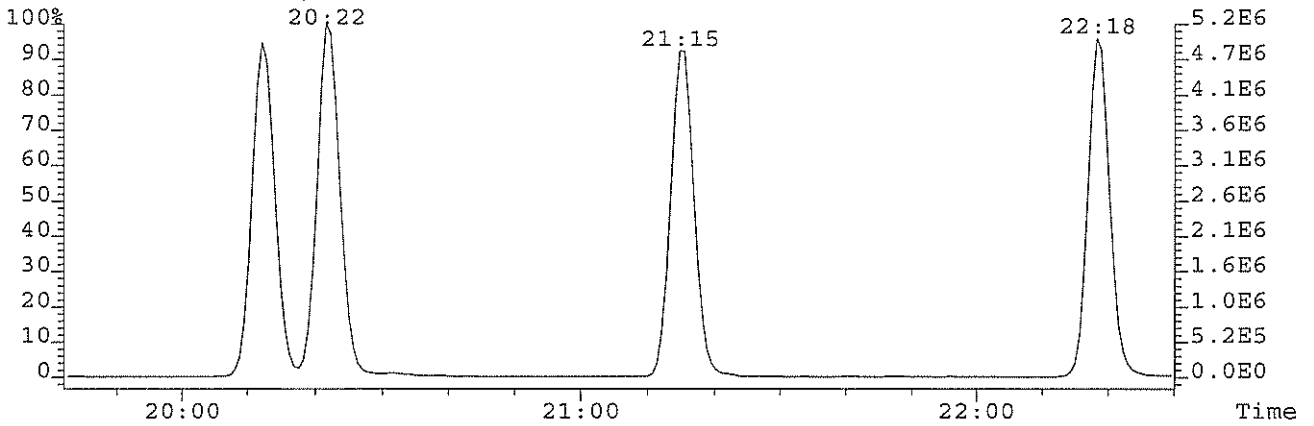
325.8804 S:23 SMO(1,3)



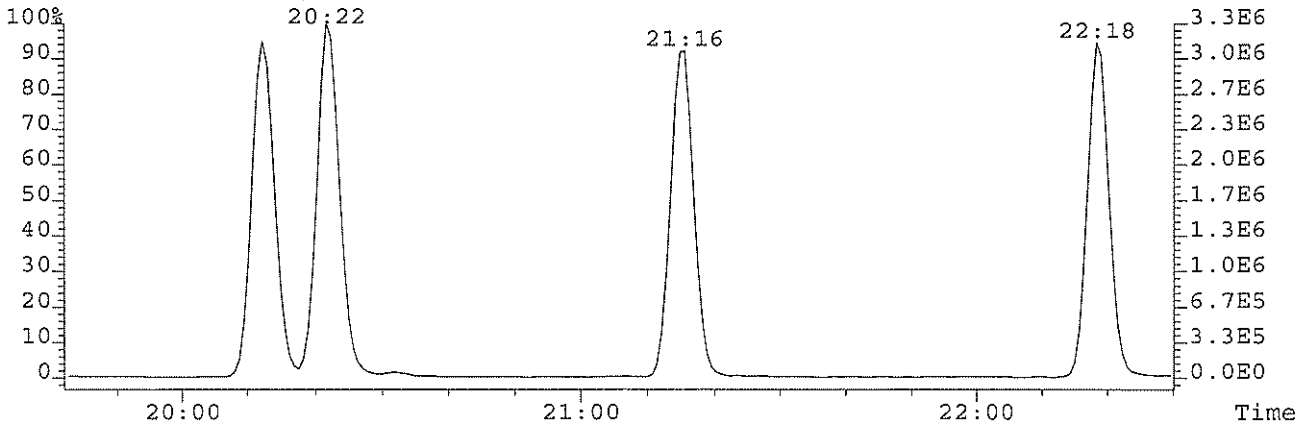
327.8775 S:23 SMO(1,3)



337.9207 S:23 SMO(1,3)

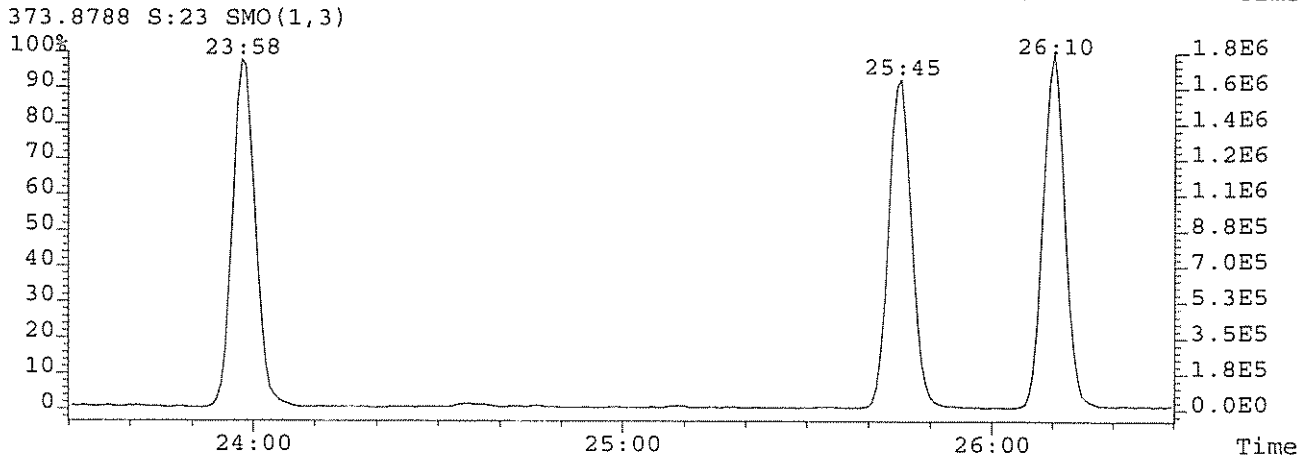
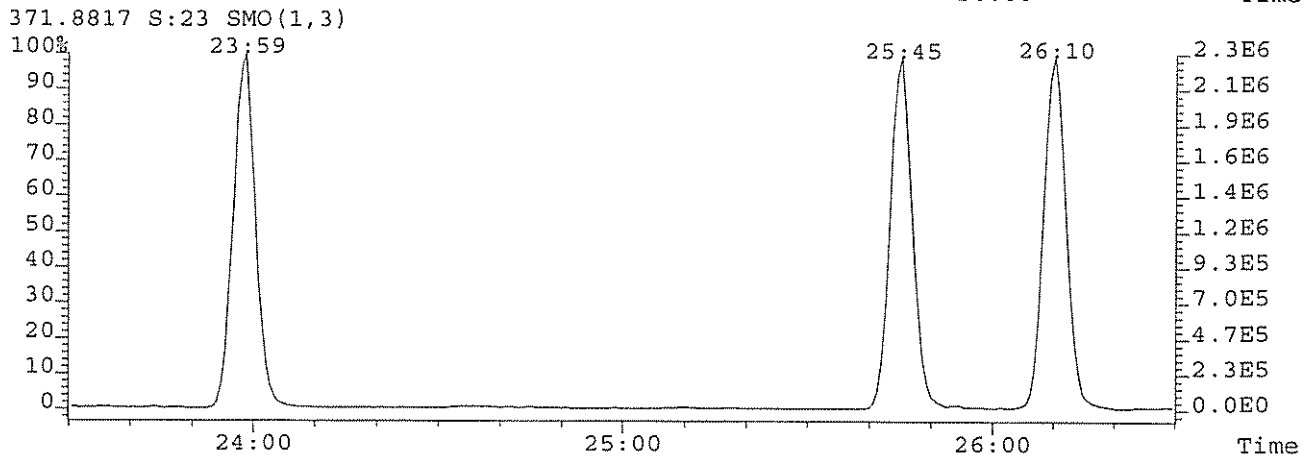
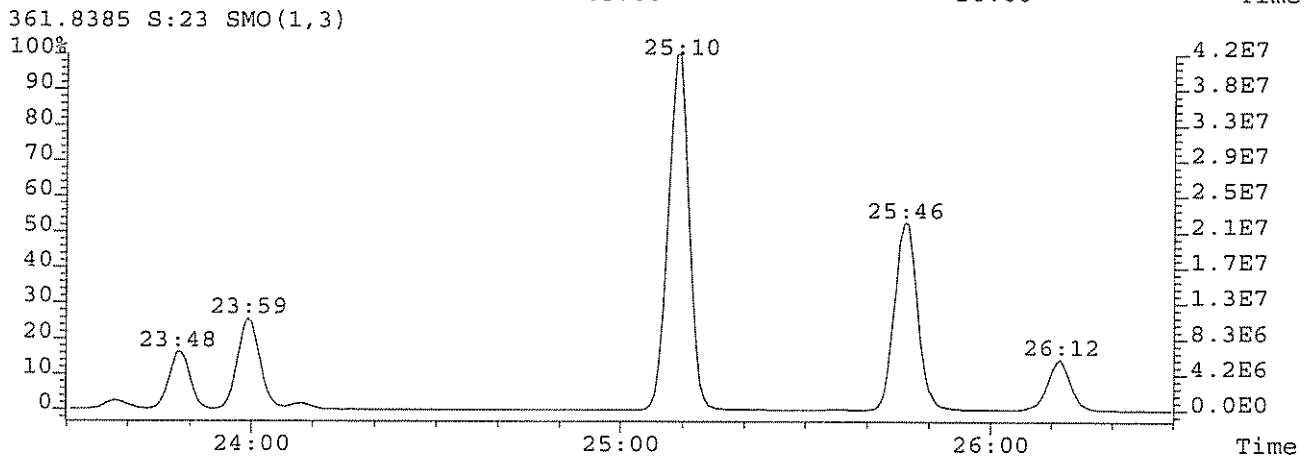
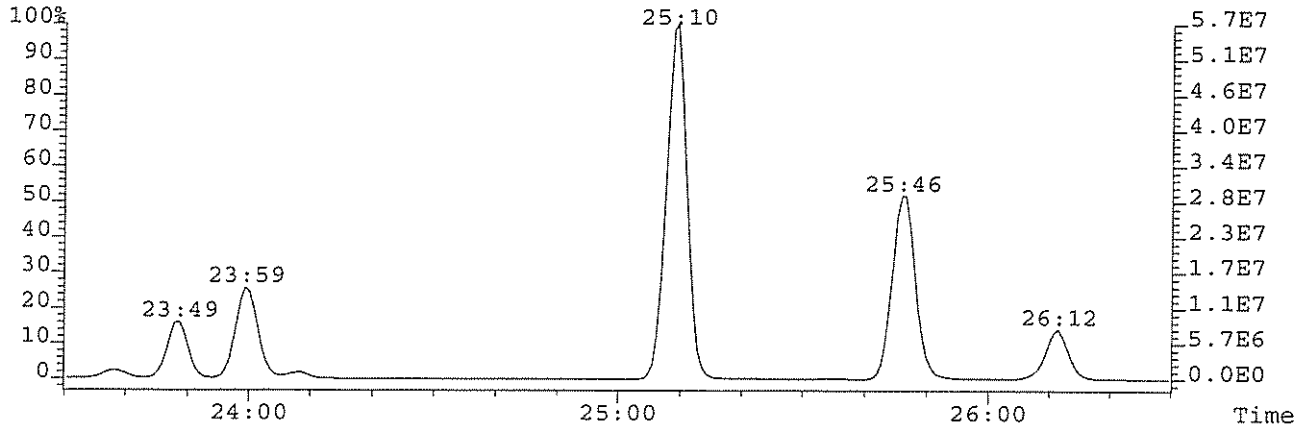


339.9178 S:23 SMO(1,3)



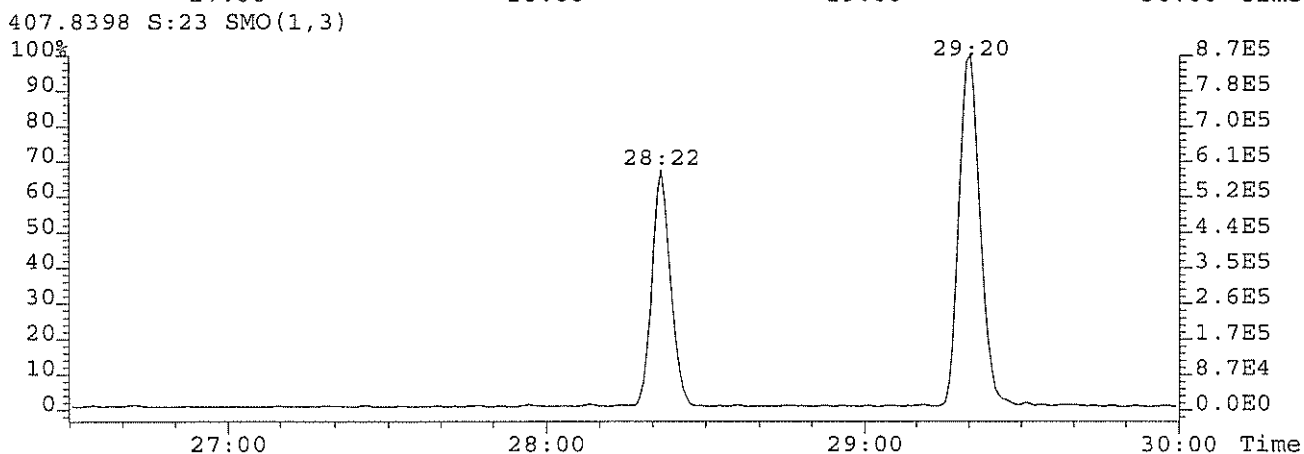
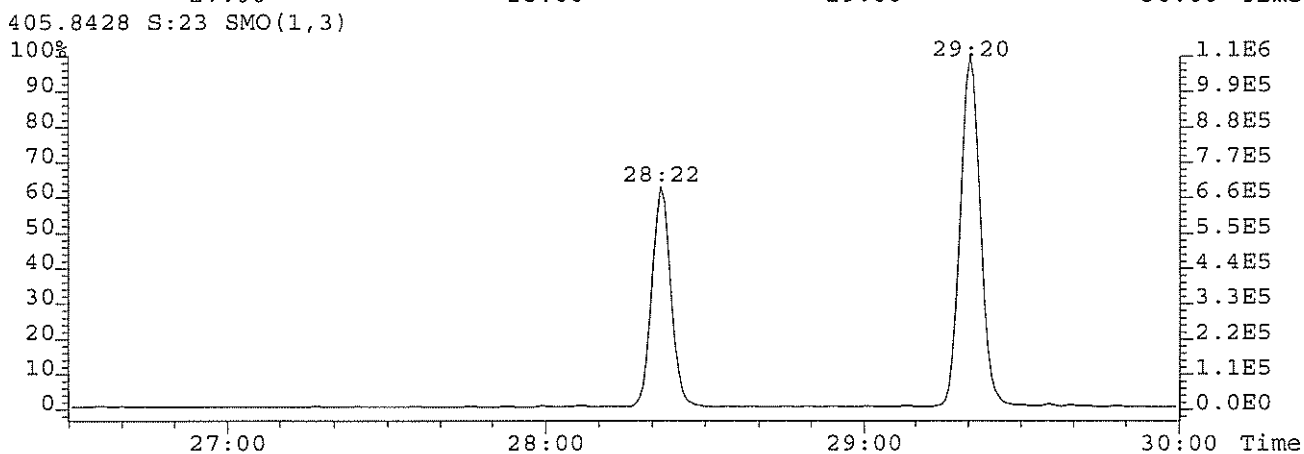
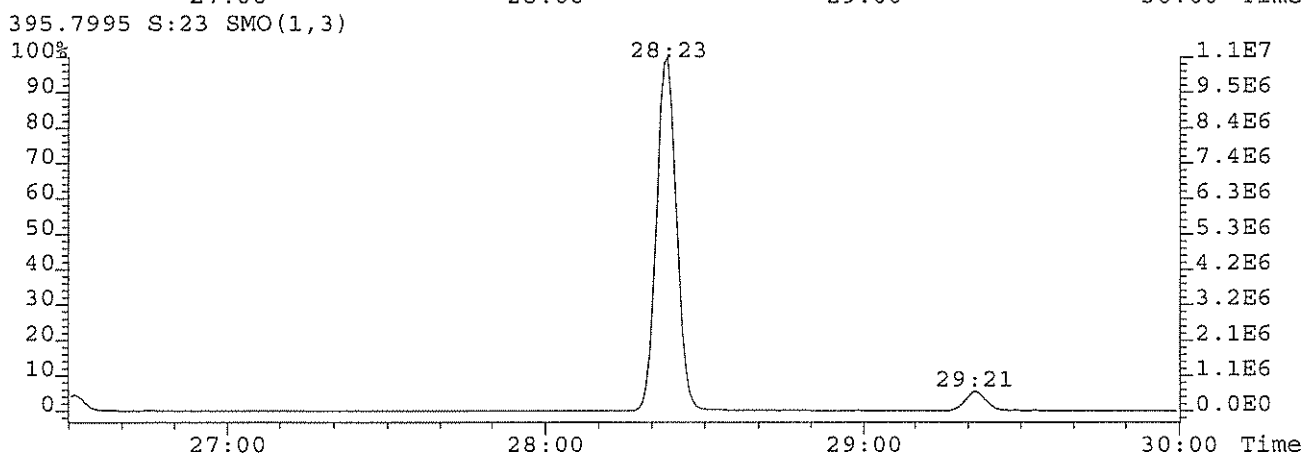
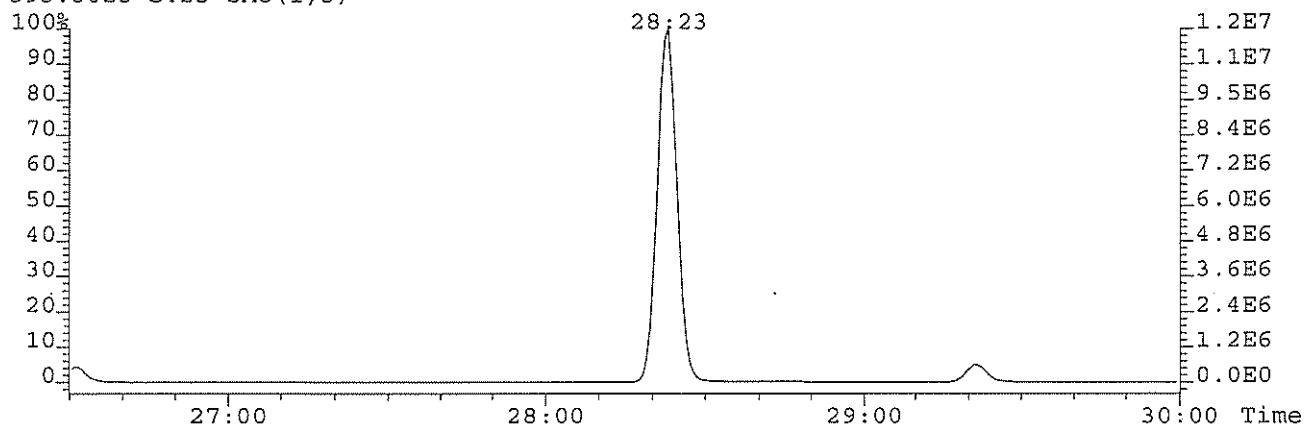
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130713 #1-2898 Acq:14-JUL-2013 03:27:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#23 File Text:RH-12ms(mP) Text:XE13 0951 2 Exp:RH-MP11  
359.8415 S:23 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

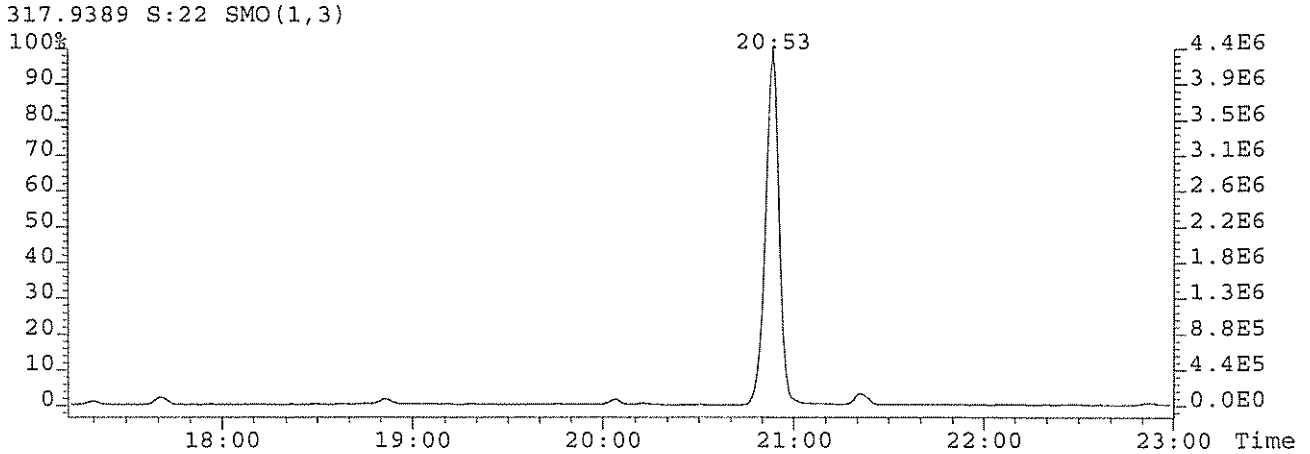
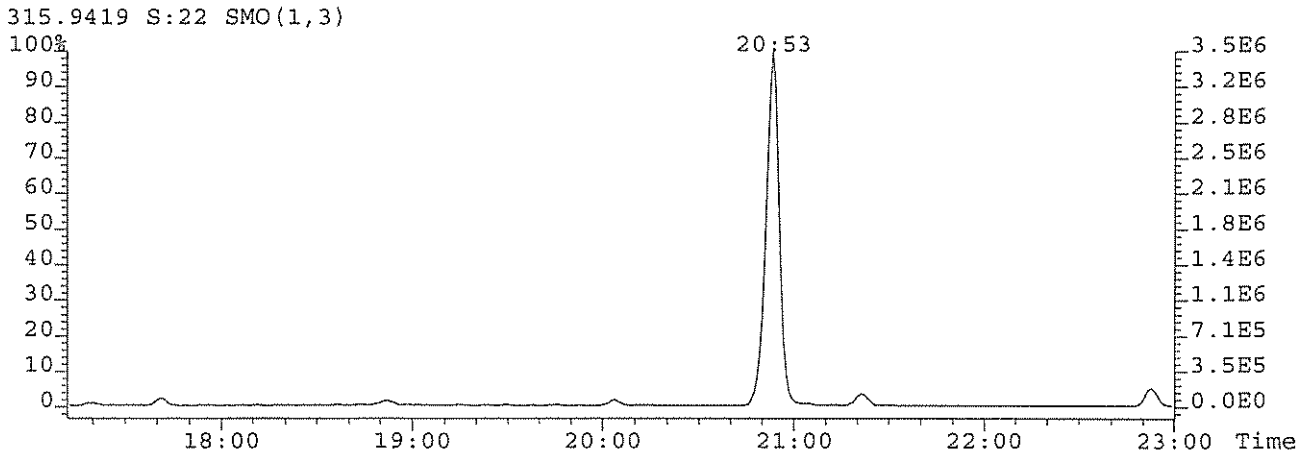
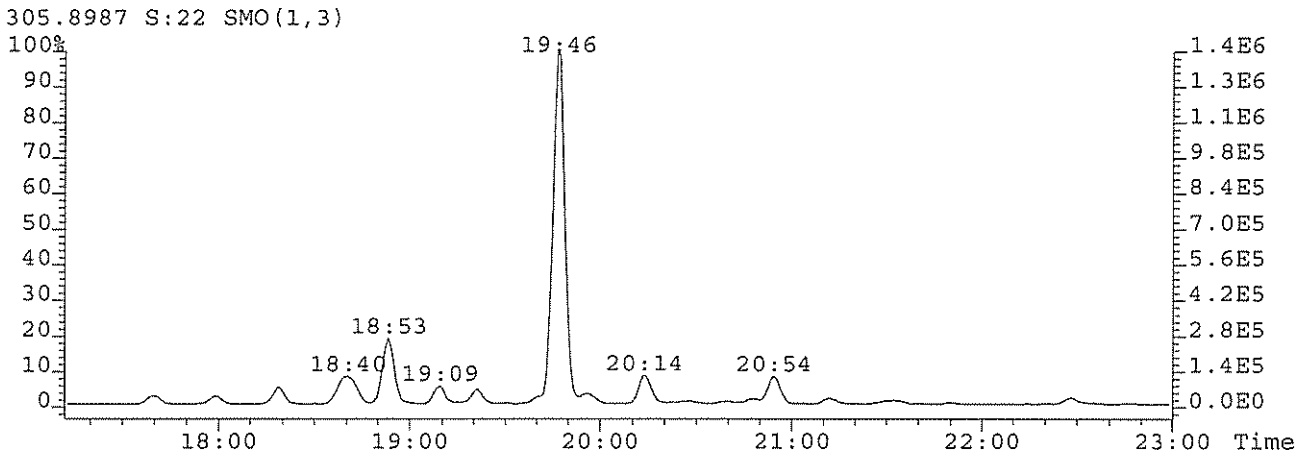
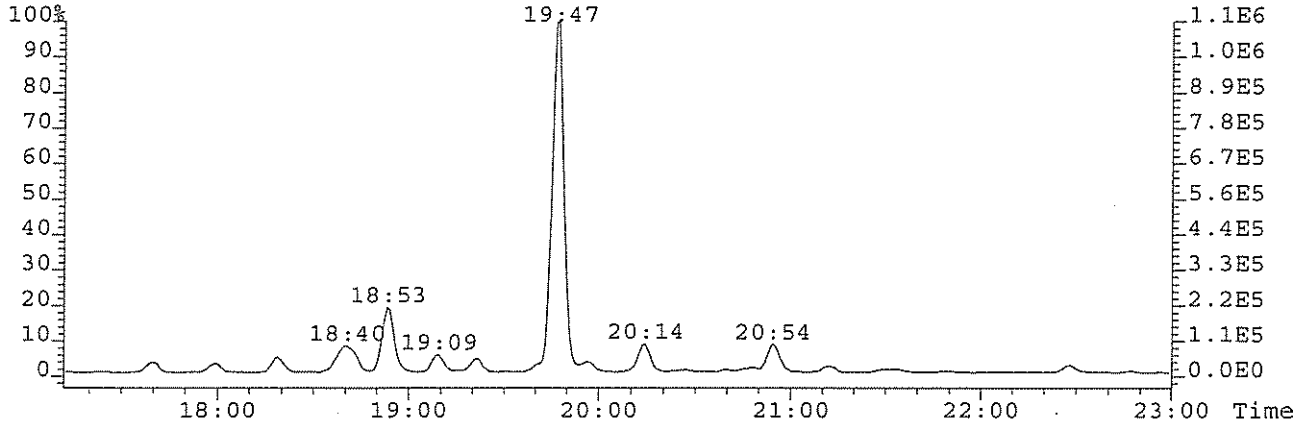
File:130713 #1-2898 Acq:14-JUL-2013 03:27:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#23 File Text:RH-12ms(mP) Text:XE13 0951 2 Exp:RH-MP11  
393.8025 S:23 SMO(1,3)



DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

試料管理番号	XE 130952
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.6

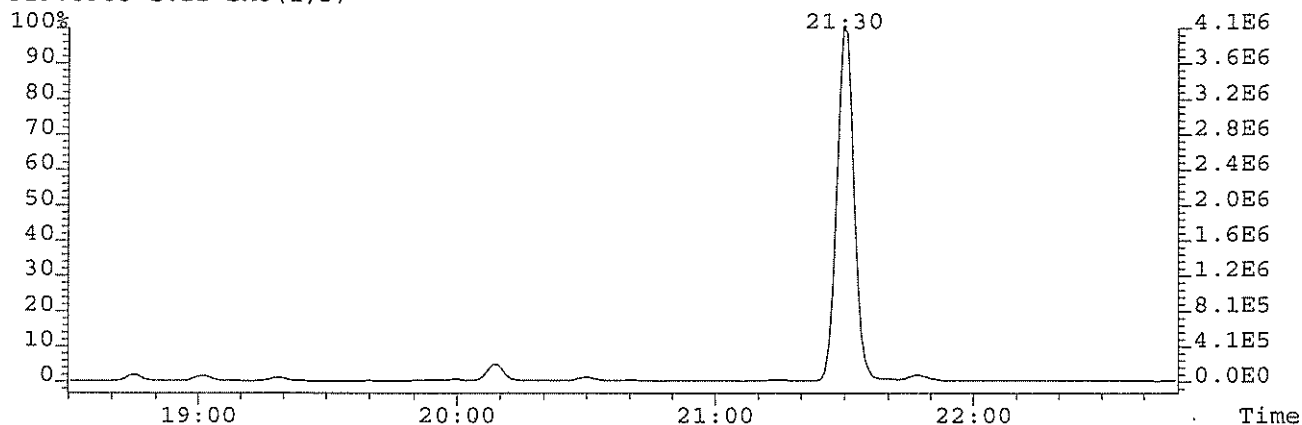
File:130710-2 #1-1578 Acq:11-JUL-2013 08:00:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:BPX-DXN(4-6DXN) Text:XE13 0952 Exp:BPX04  
303.9016 S:22 SMO(1,3)



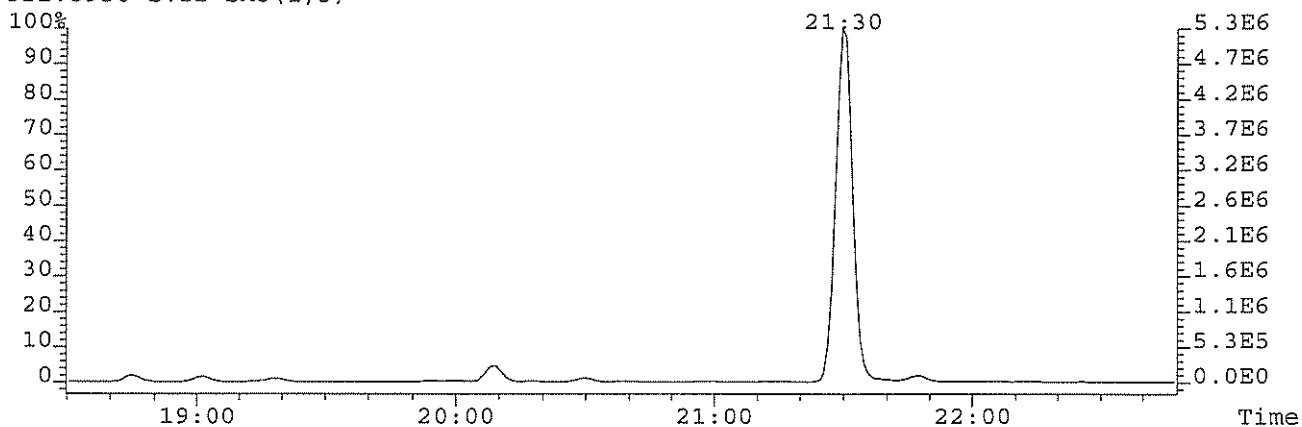
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130710-2 #1-1578 Acq:11-JUL-2013 08:00:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:BPX-DXN(4-6DXN) Text:XE13 0952 Exp:BPX04

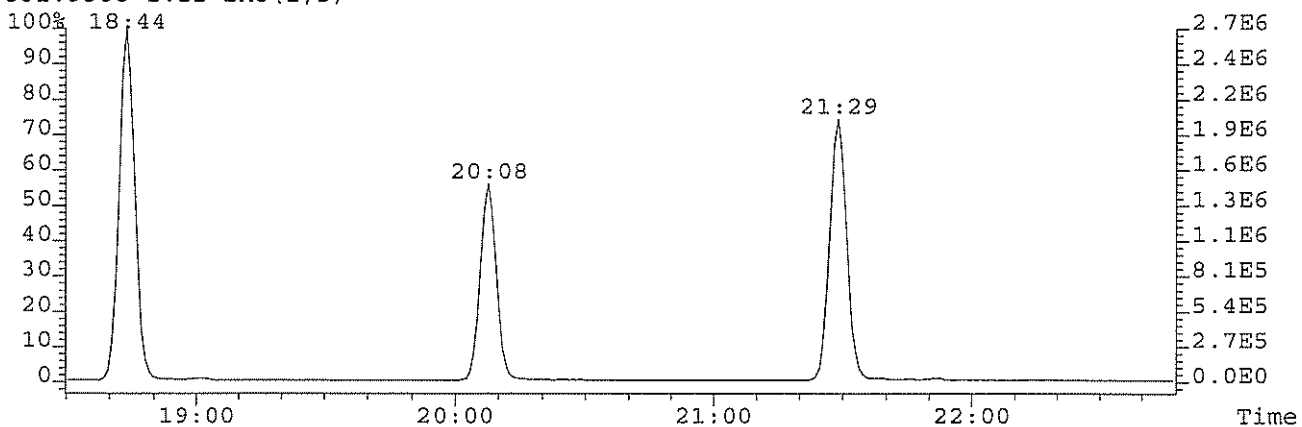
319.8965 S:22 SMO(1,3)



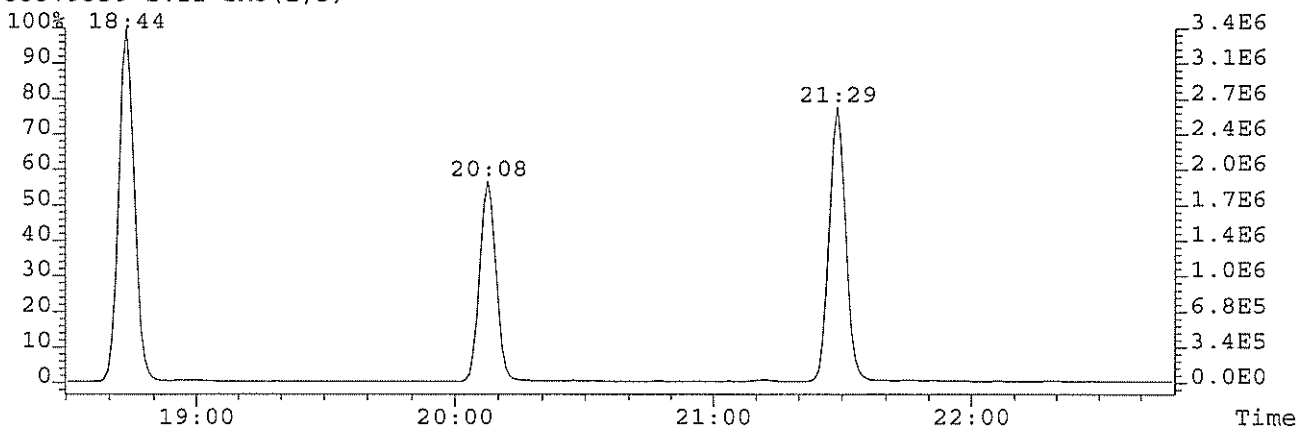
321.8936 S:22 SMO(1,3)



331.9368 S:22 SMO(1,3)



333.9339 S:22 SMO(1,3)

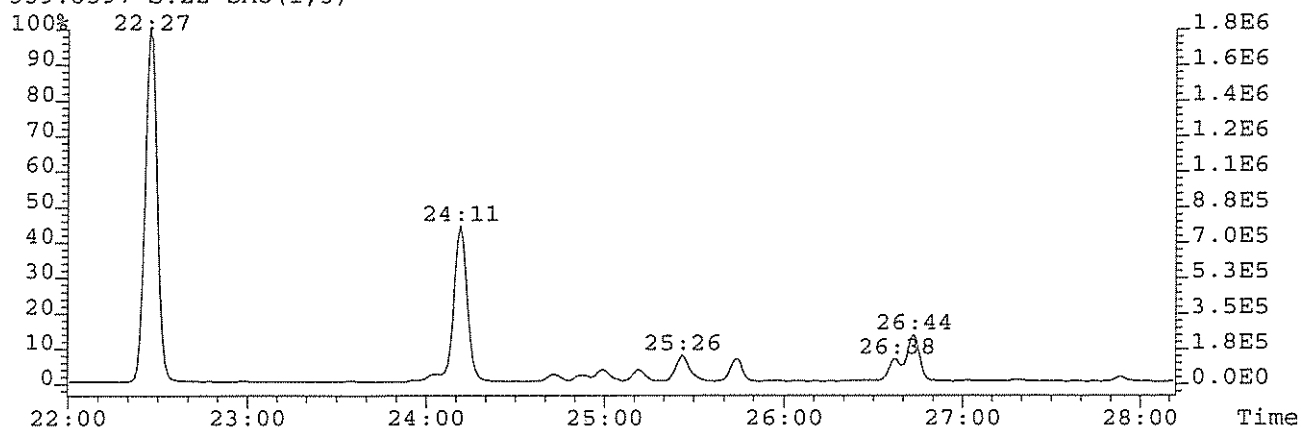


PCDDsクロマトグラム (2)  
(TeCDDs)

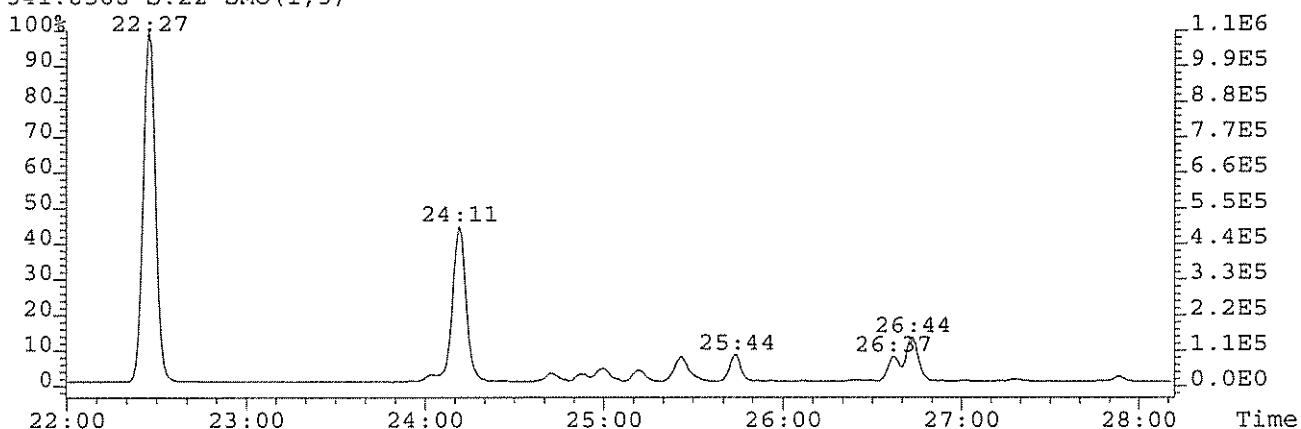


File:130710-2 #1-1578 Acq:11-JUL-2013 08:00:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:BPX-DXN(4-6DXN) Text:XR13 0952 Exp:BPX04

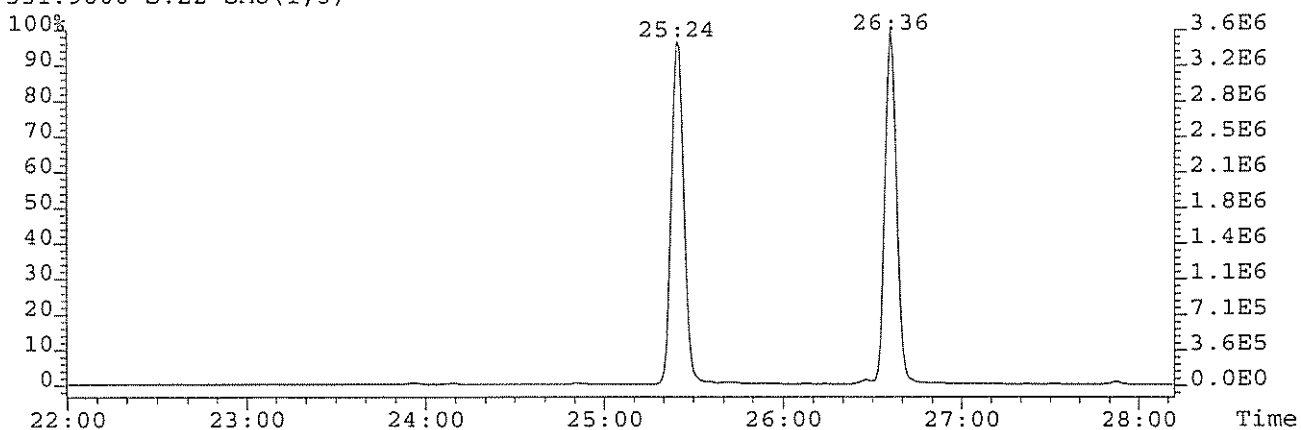
339.8597 S:22 SMO(1,3)



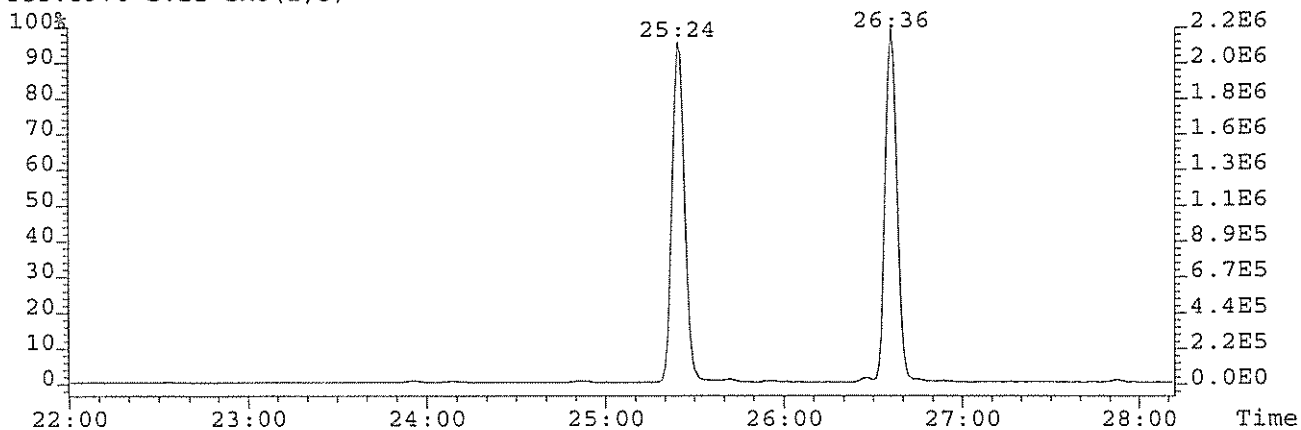
341.8568 S:22 SMO(1,3)



351.9000 S:22 SMO(1,3)



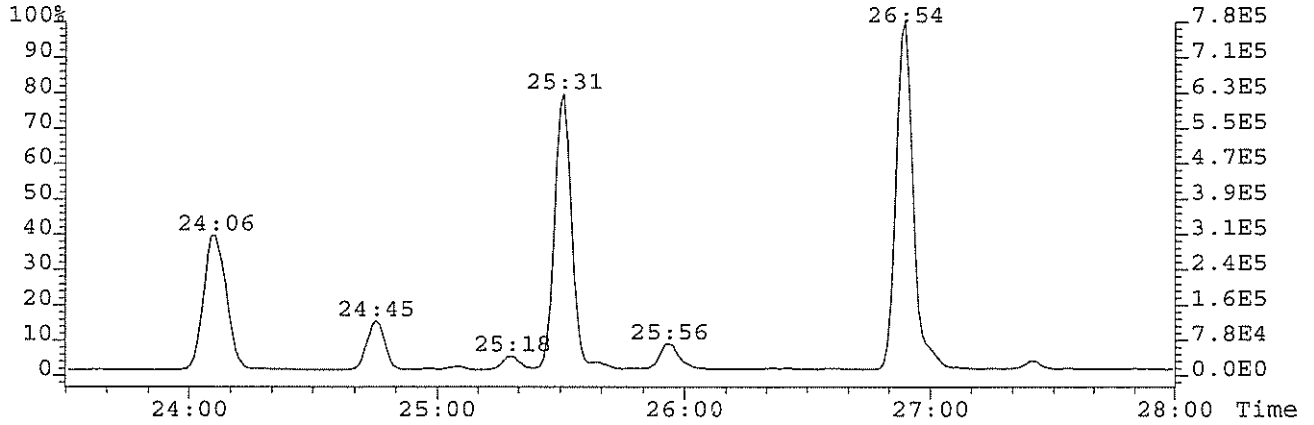
353.8970 S:22 SMO(1,3)



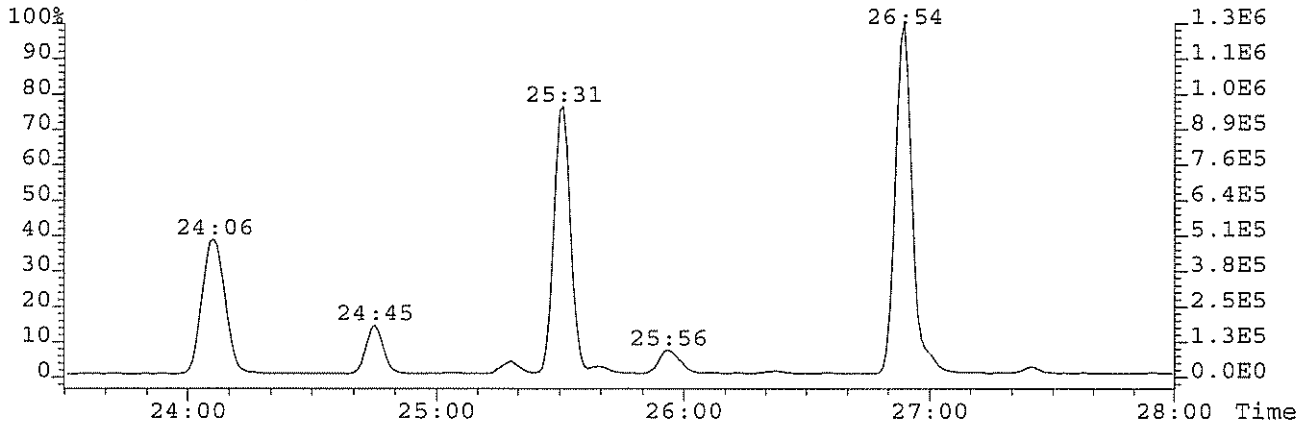
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130710-2 #1-1578 Acq:11-JUL-2013 08:00:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:BPX-DXN(4-6DXN) Text:XE13 0952 Exp:BPX04

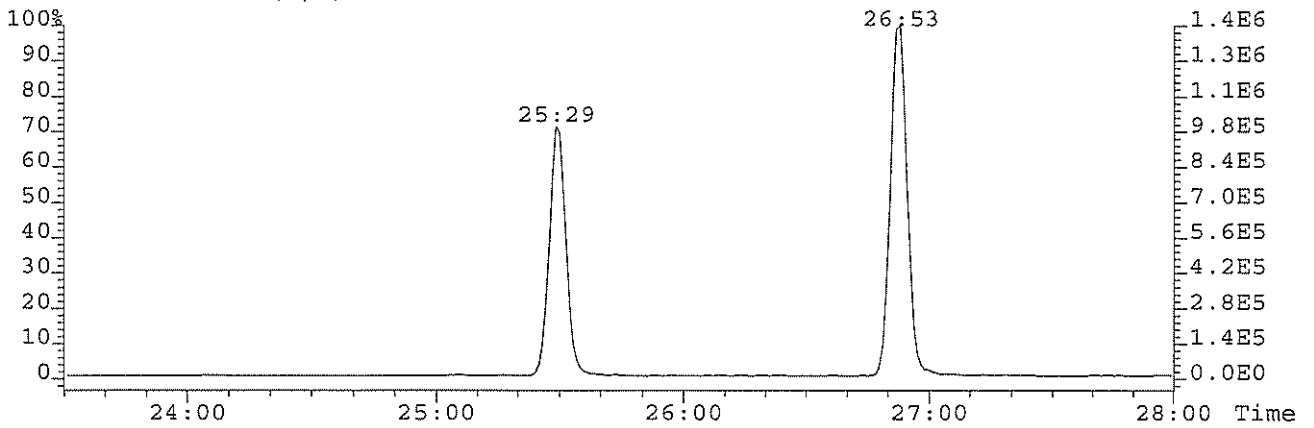
353.8576 S:22 SMO(1,3)



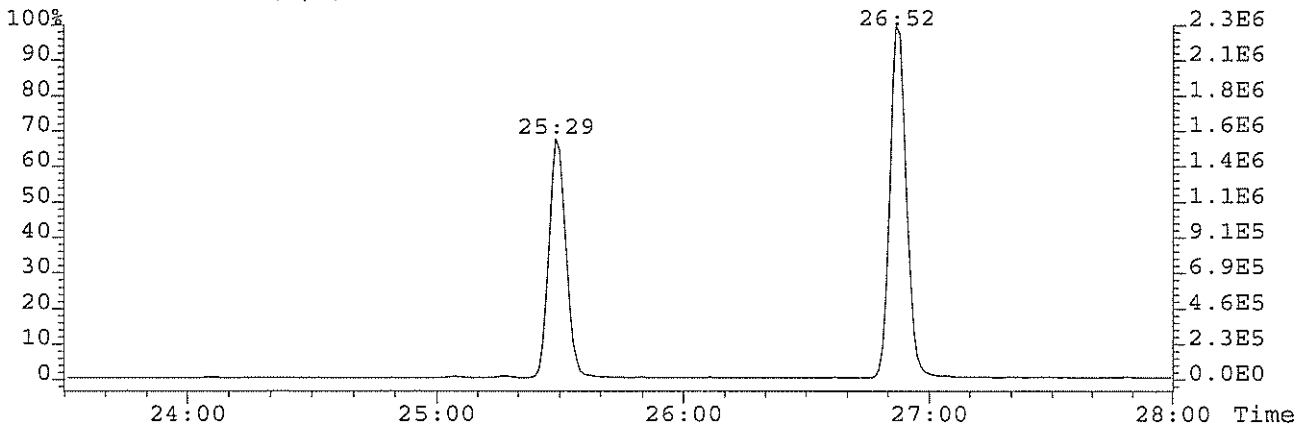
355.8546 S:22 SMO(1,3)



365.8978 S:22 SMO(1,3)

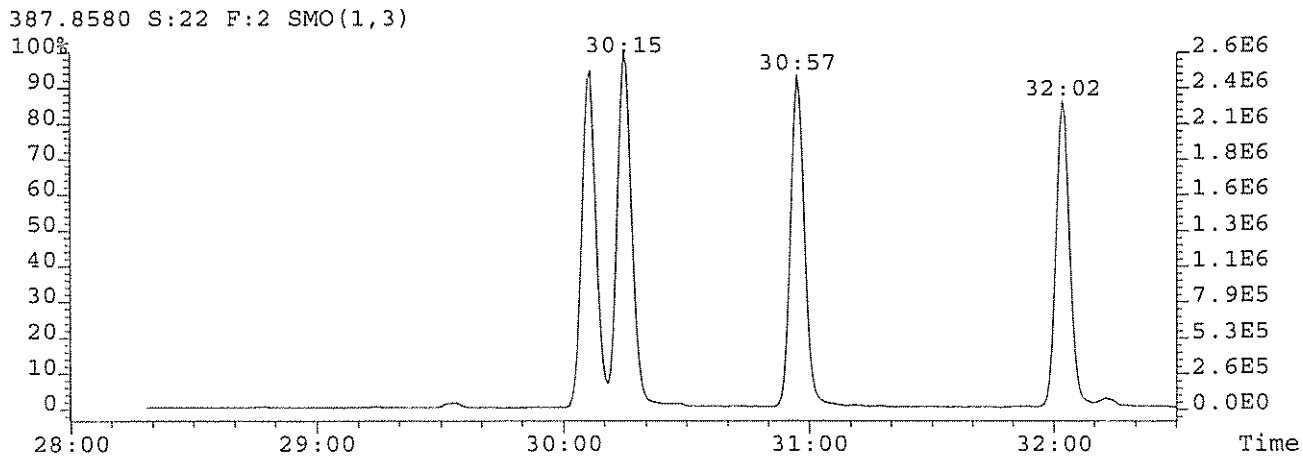
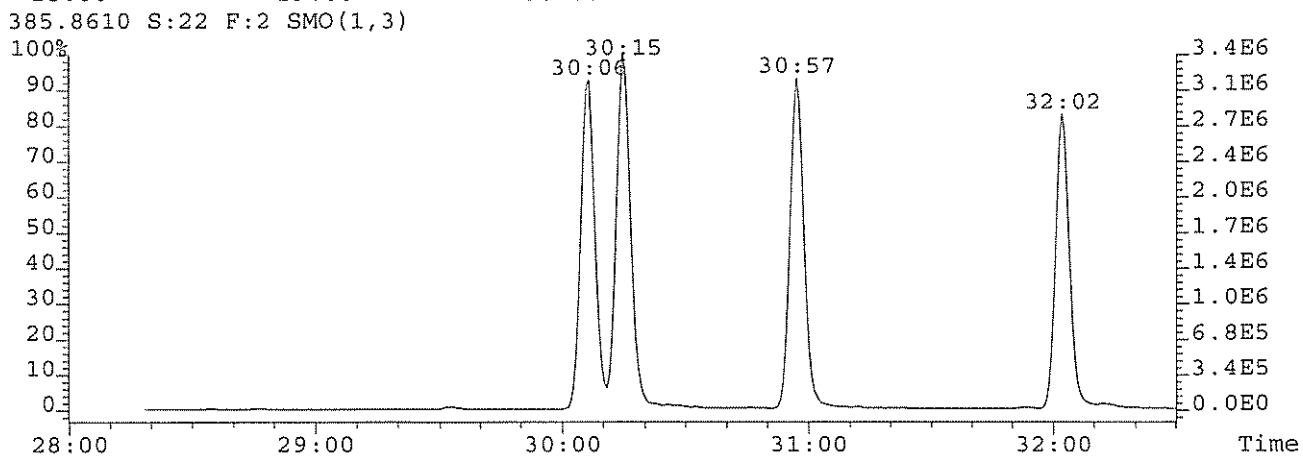
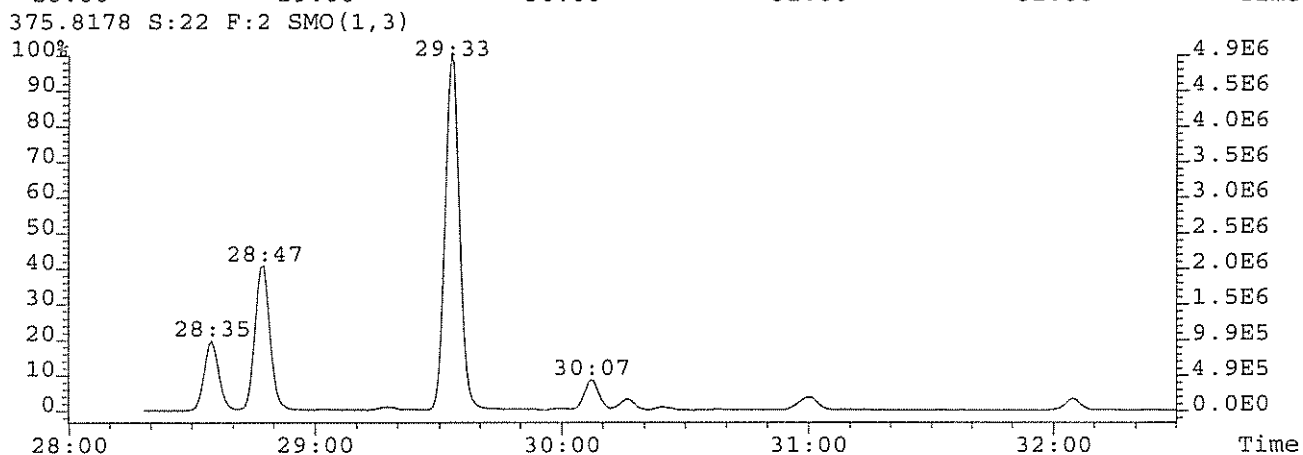
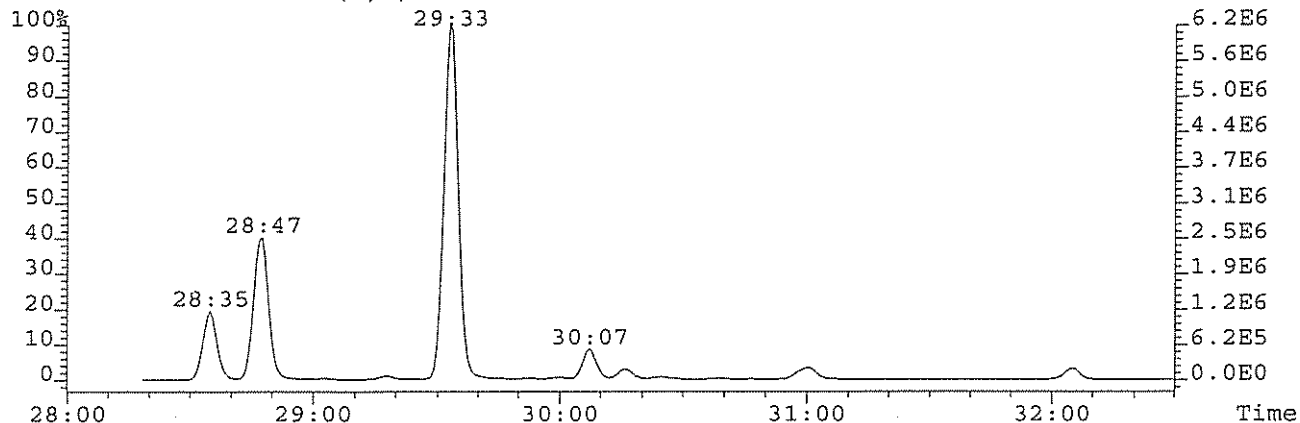


367.8949 S:22 SMO(1,3)



PCDDsクロマトグラム (4)  
(PeCDDs)

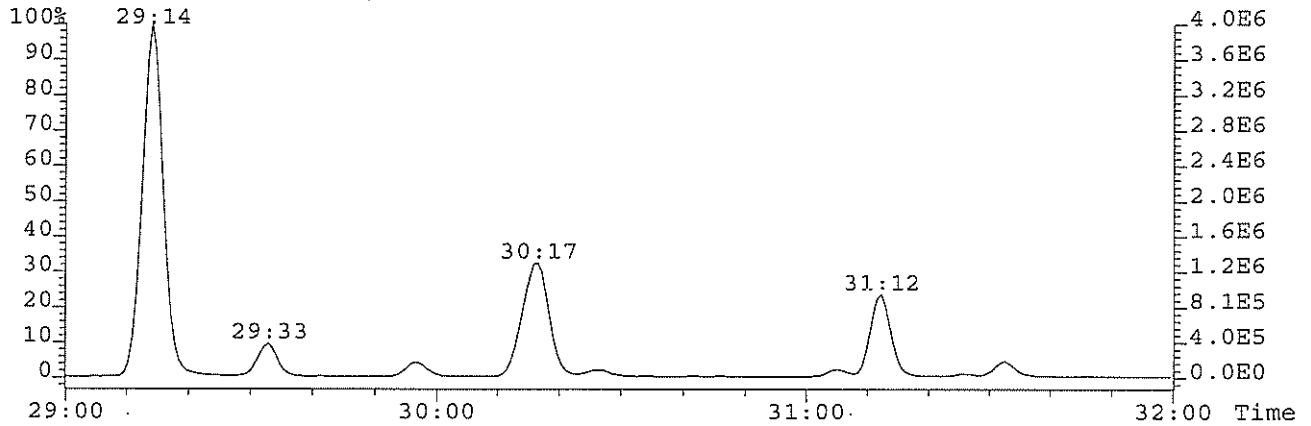
File:130710-2 #1-1116 Acq:11-JUL-2013 08:00:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:BPX-DXN(4-6DXN) Text:XE13 0952 Exp:BPX04  
373.8207 S:22 F:2 SMO(1,3)



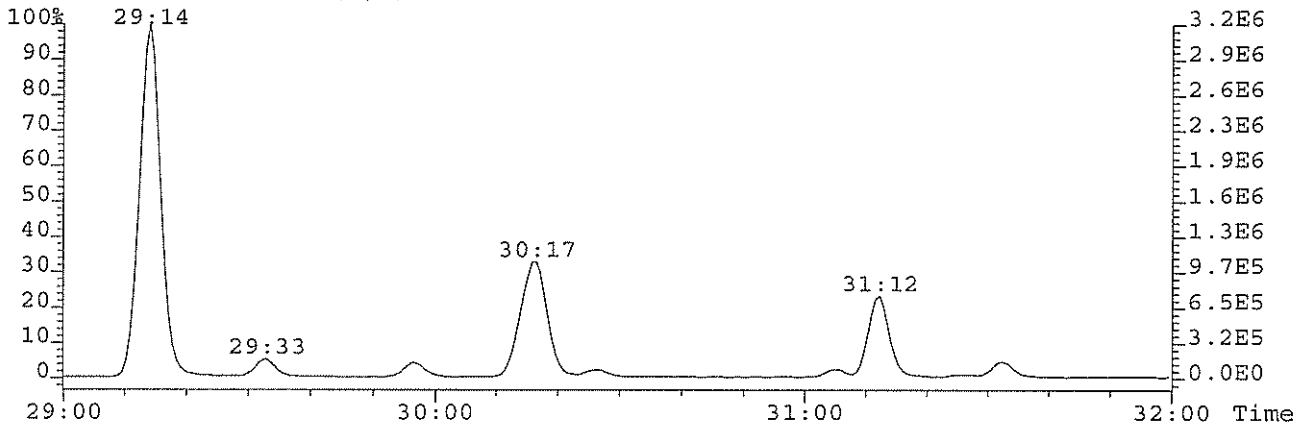
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130710-2 #1-1116 Acq:11-JUL-2013 08:00:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:BPX-DXN(4-6DXN) Text:XE13 0952 Exp:BPX04

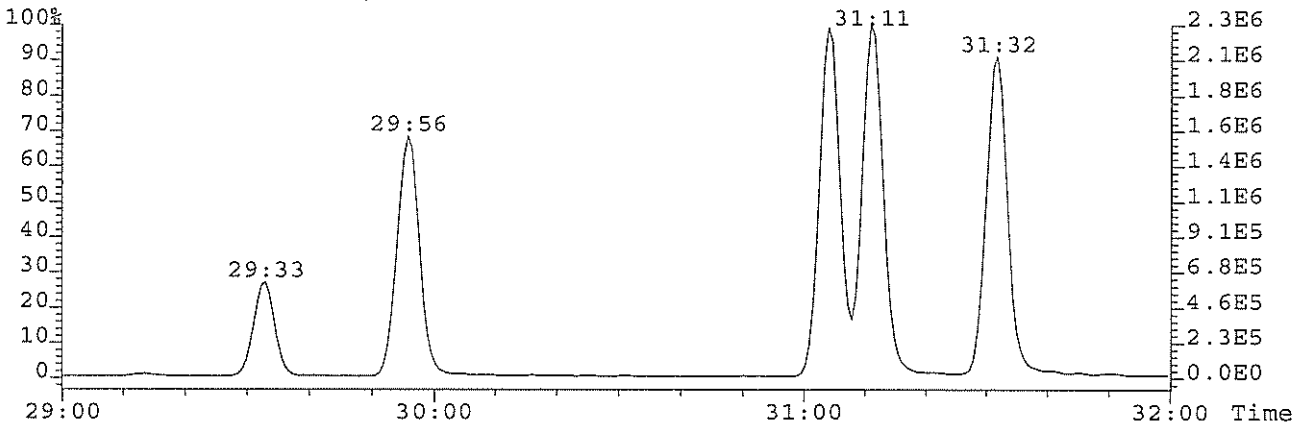
389.8156 S:22 F:2 SMO(1,3)



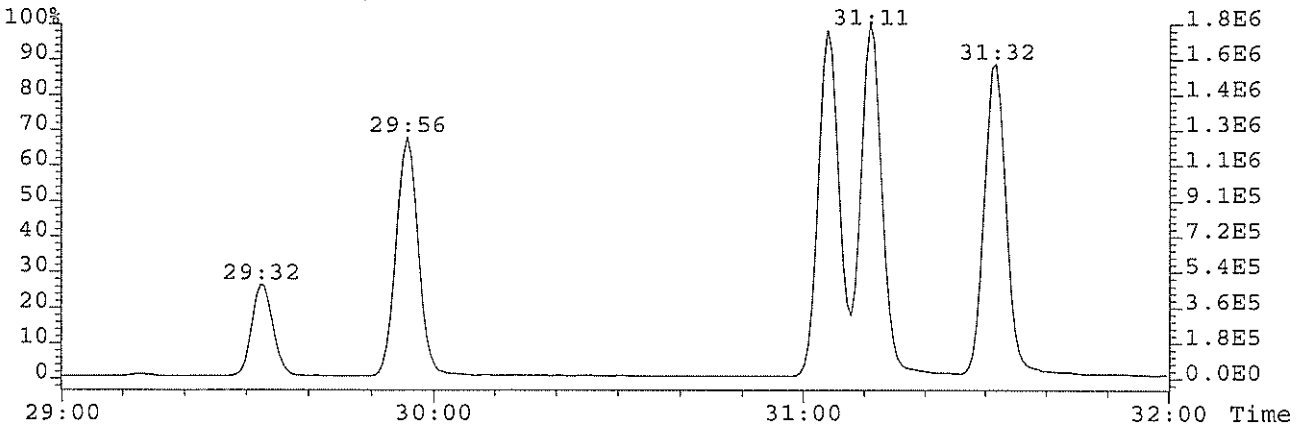
391.8127 S:22 F:2 SMO(1,3)



401.8559 S:22 F:2 SMO(1,3)

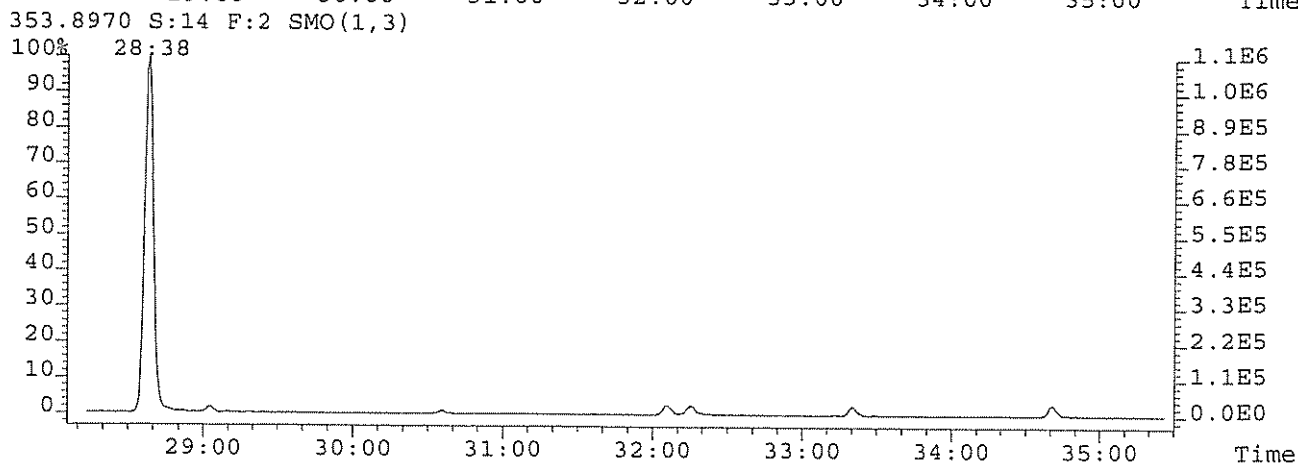
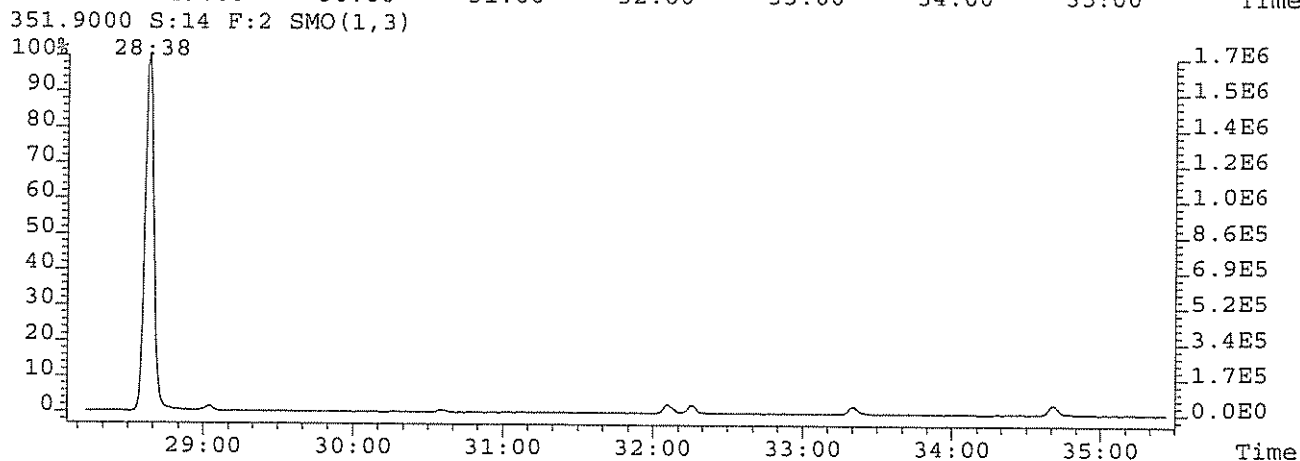
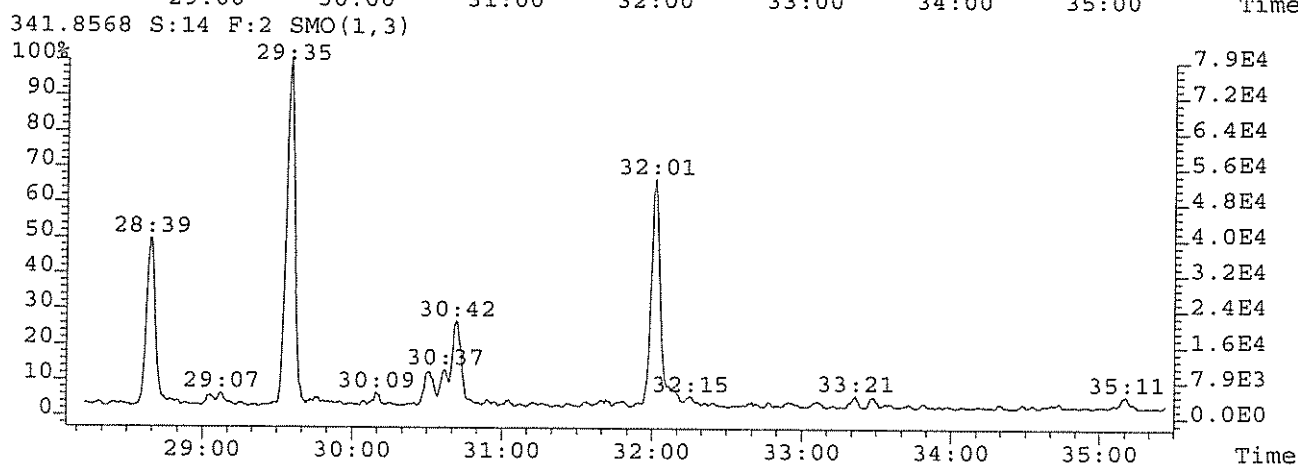
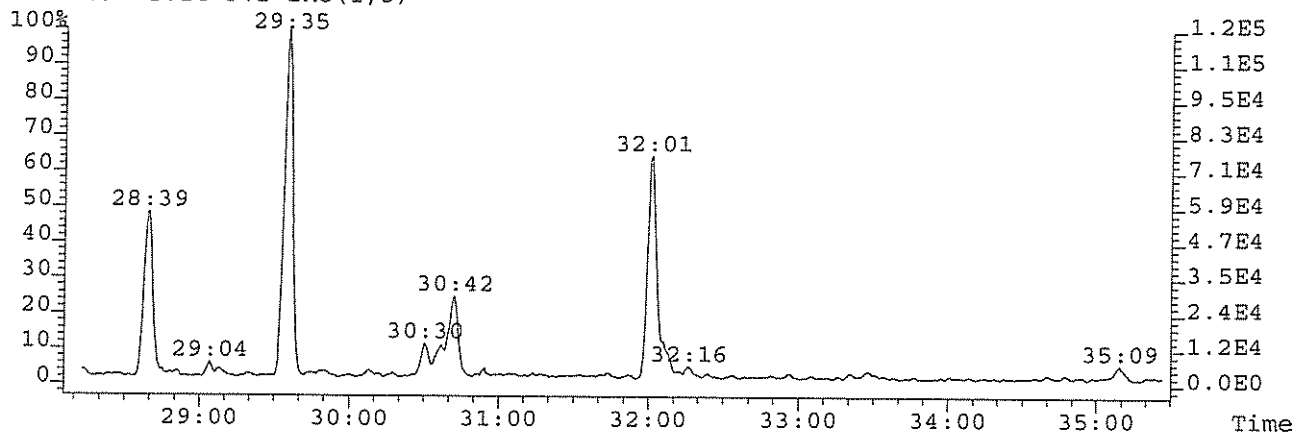


403.8530 S:22 F:2 SMO(1,3)



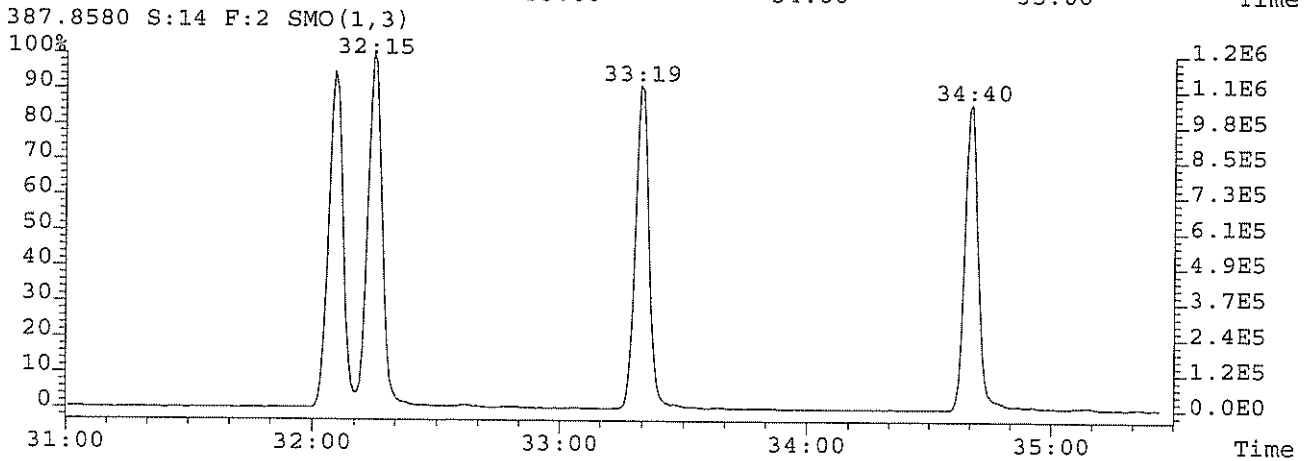
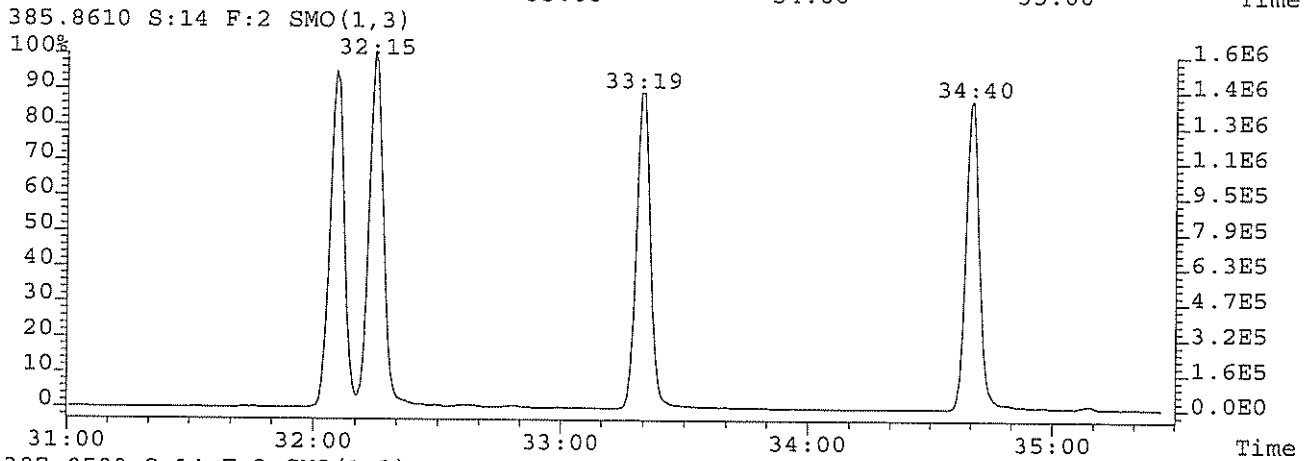
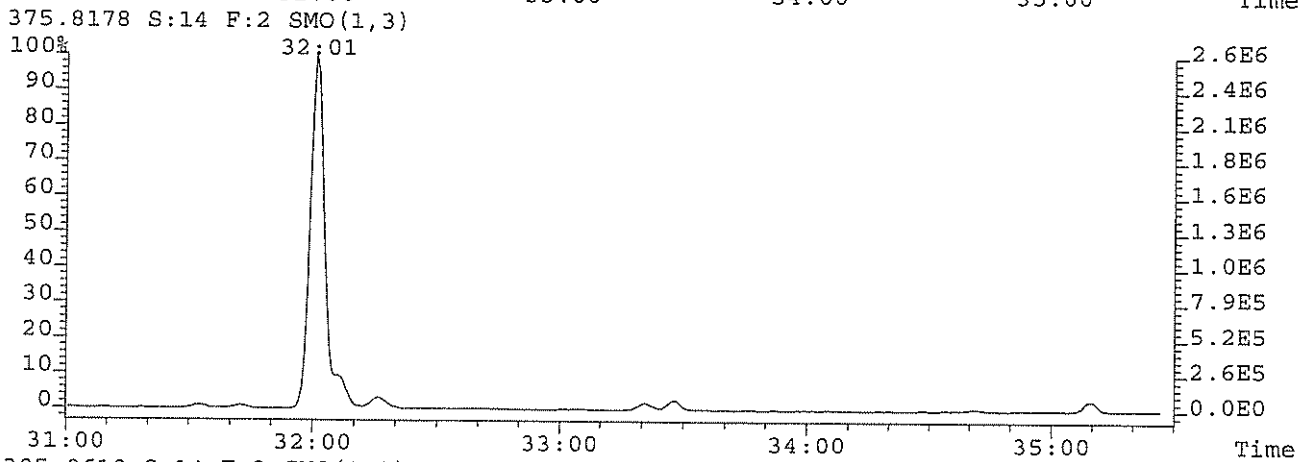
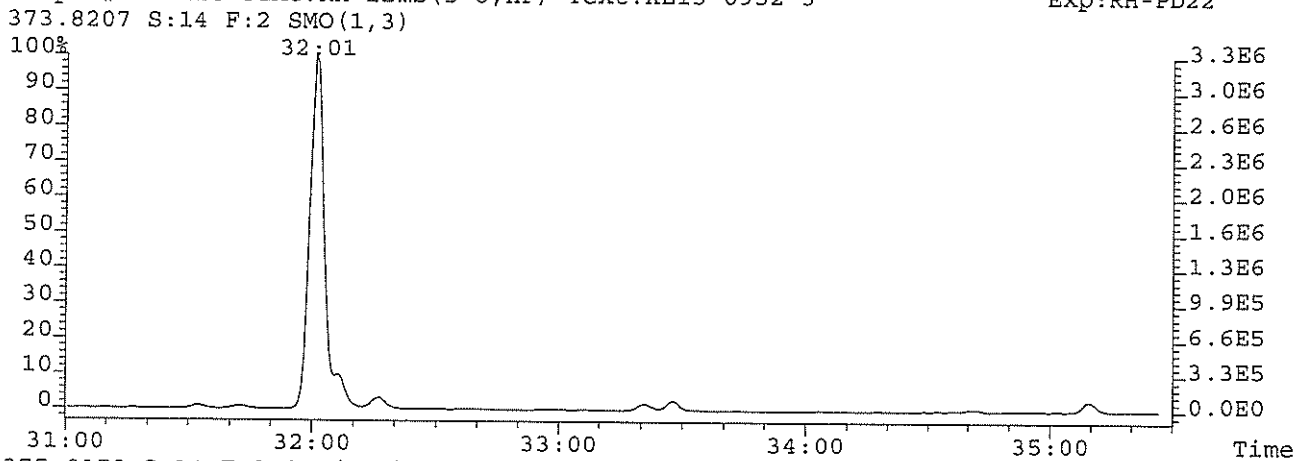
PCDDsクロマトグラム (6)  
(HxCDDs)

File:130711-2 #1-649 Acq:12-JUL-2013 05:36:30 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:RH-12ms(5-8,nP) Text:XE13 0952 3 Exp:RH-PD22  
339.8597 S:14 F:2 SMO(1,3)



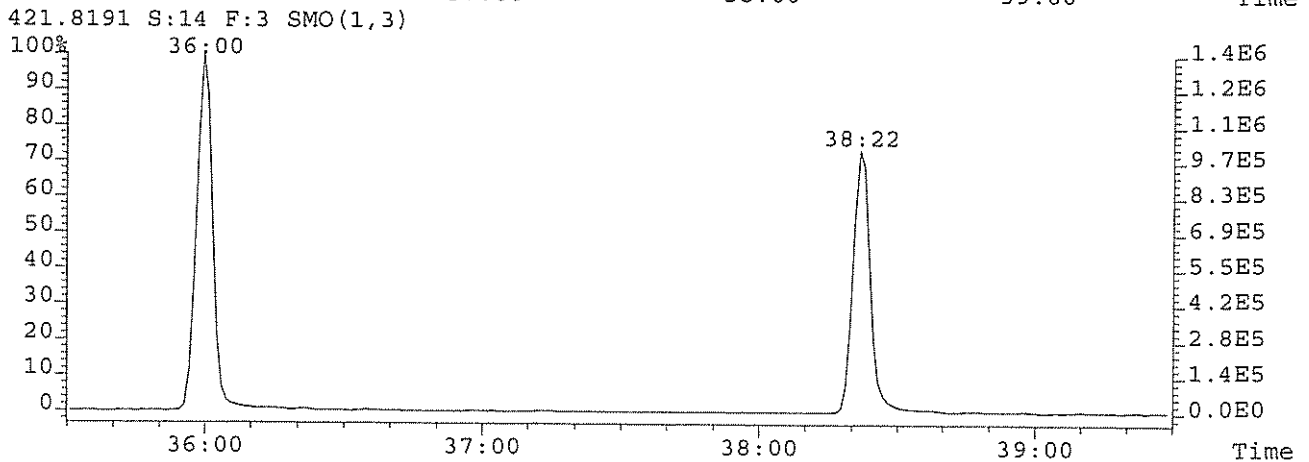
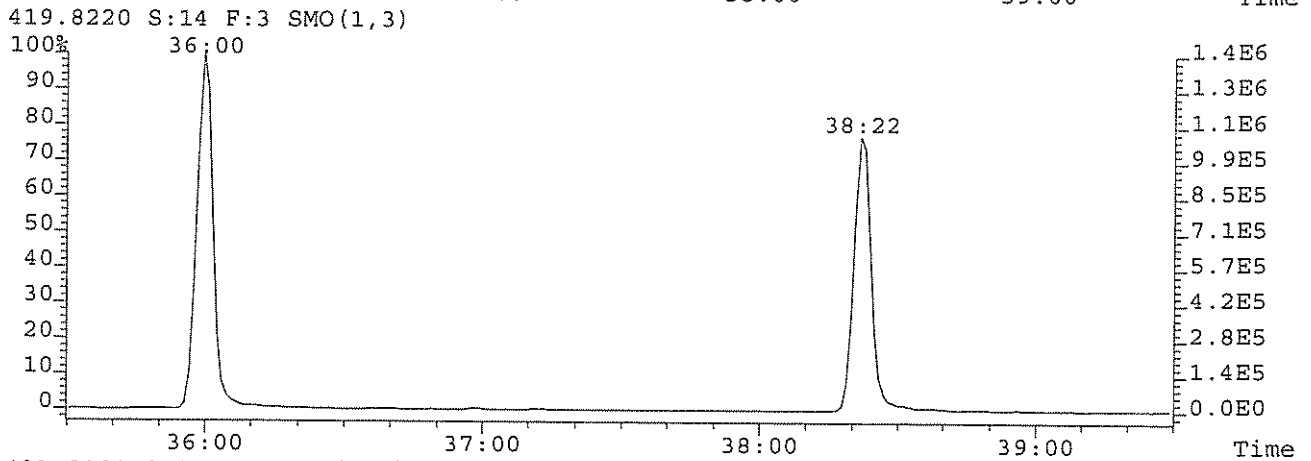
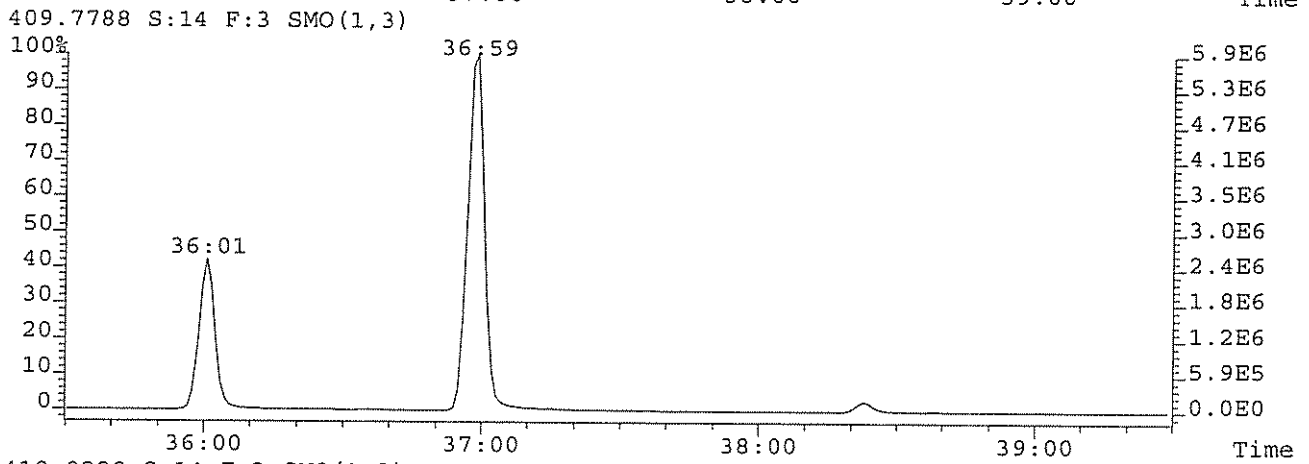
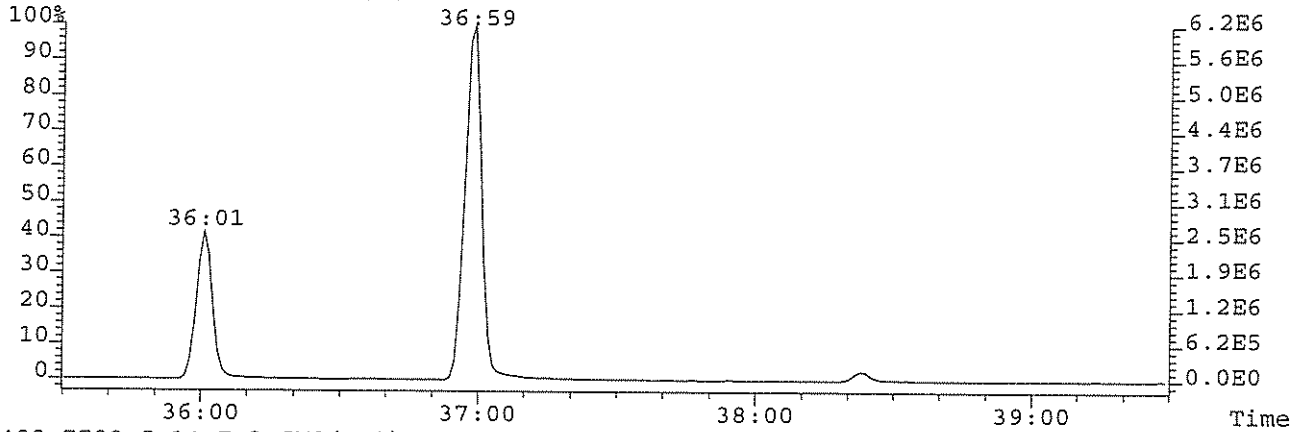
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130711-2 #1-649 Acq:12-JUL-2013 05:36:30 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:RH-12ms(5-8,nP) Text:XE13 0952 3 Exp:RH-PD22



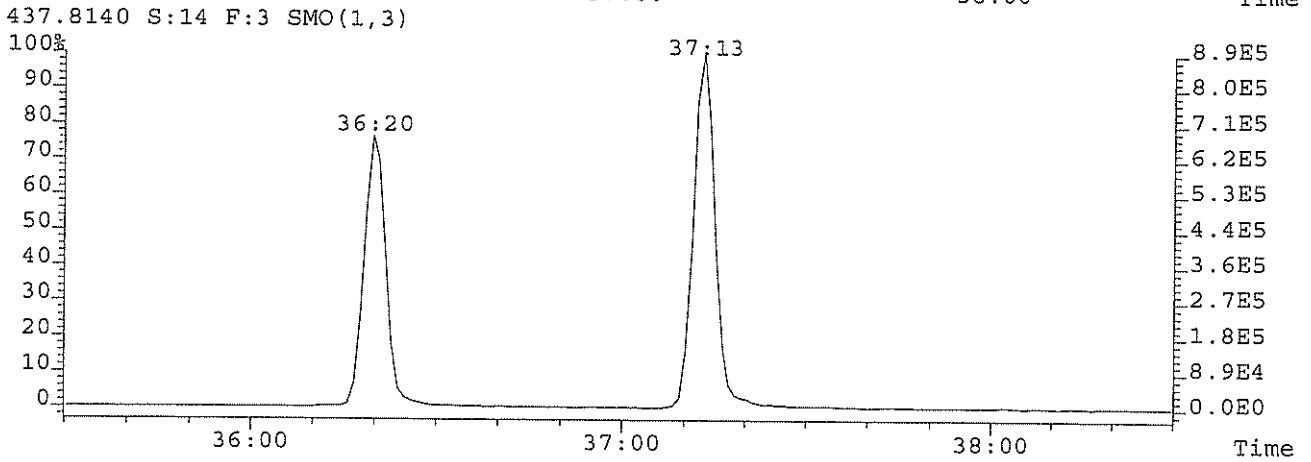
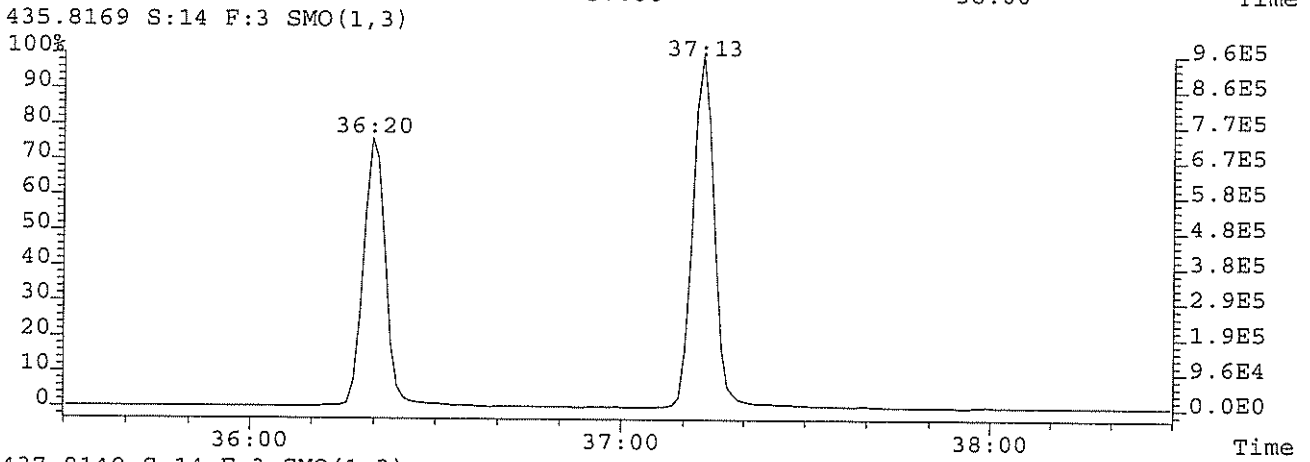
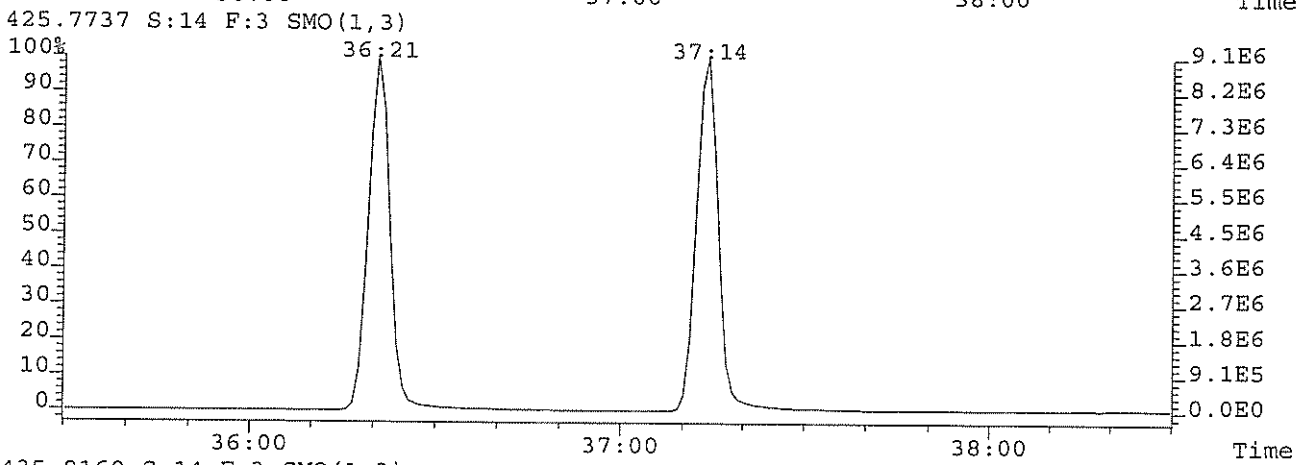
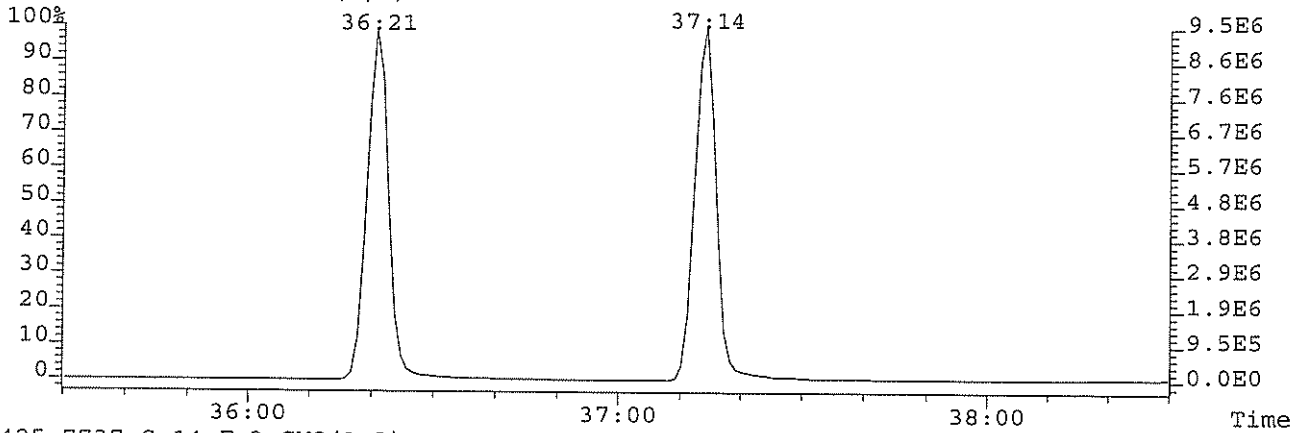
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130711-2 #1-561 Acq:12-JUL-2013 05:36:30 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:RH-12ms(5-8,nP) Text:XE13 0952 3 Exp:RH-PD22  
407.7818 S:14 F:3 SMO(1,3)



PCDFsクロマトグラム (9)  
(HpCDFs)

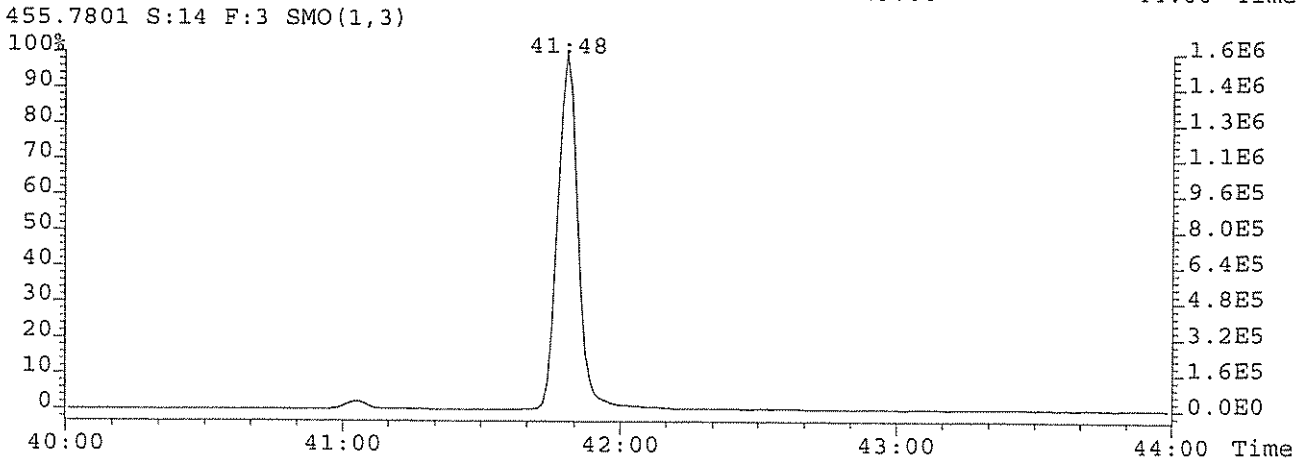
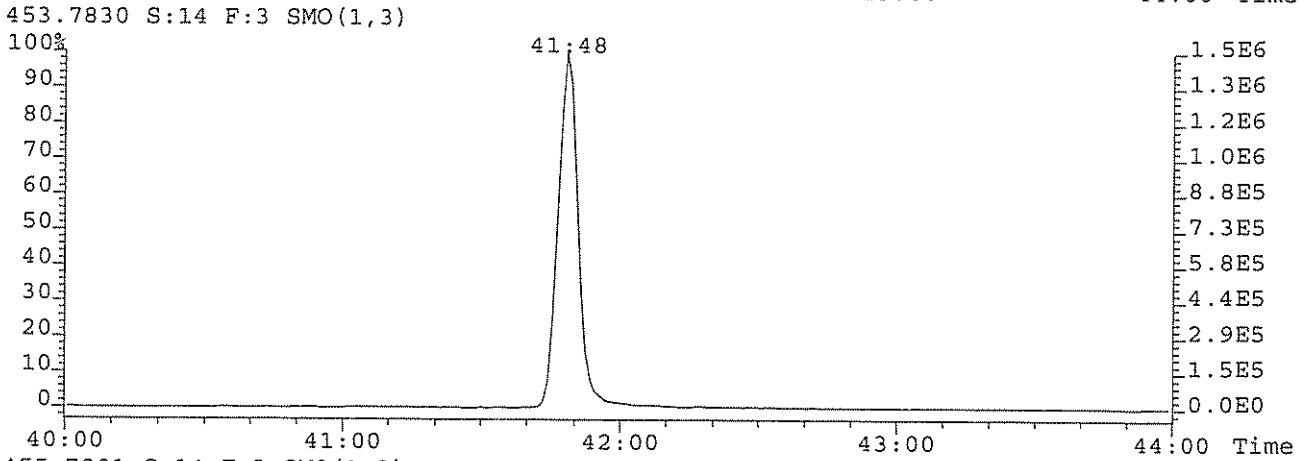
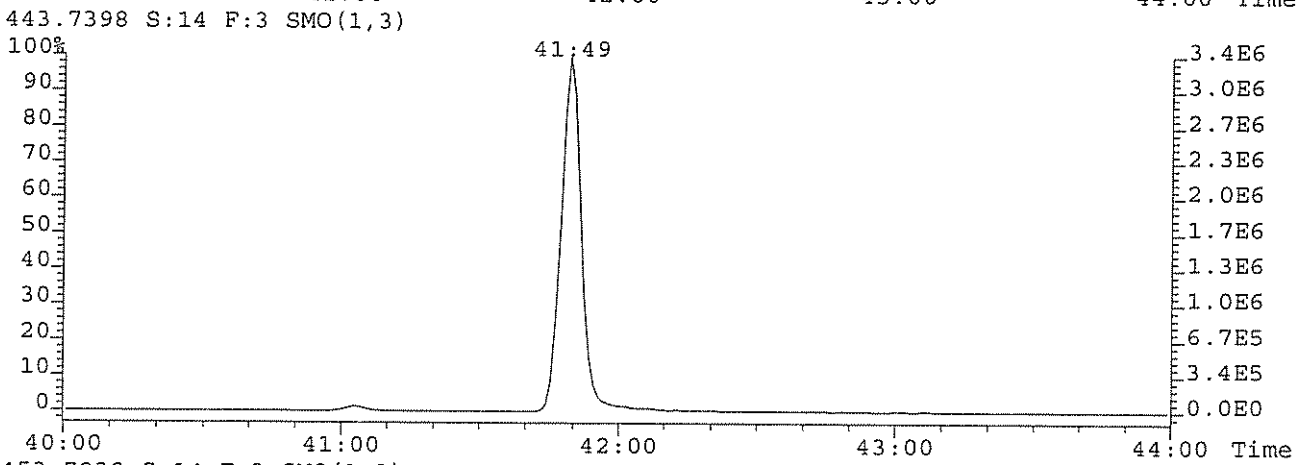
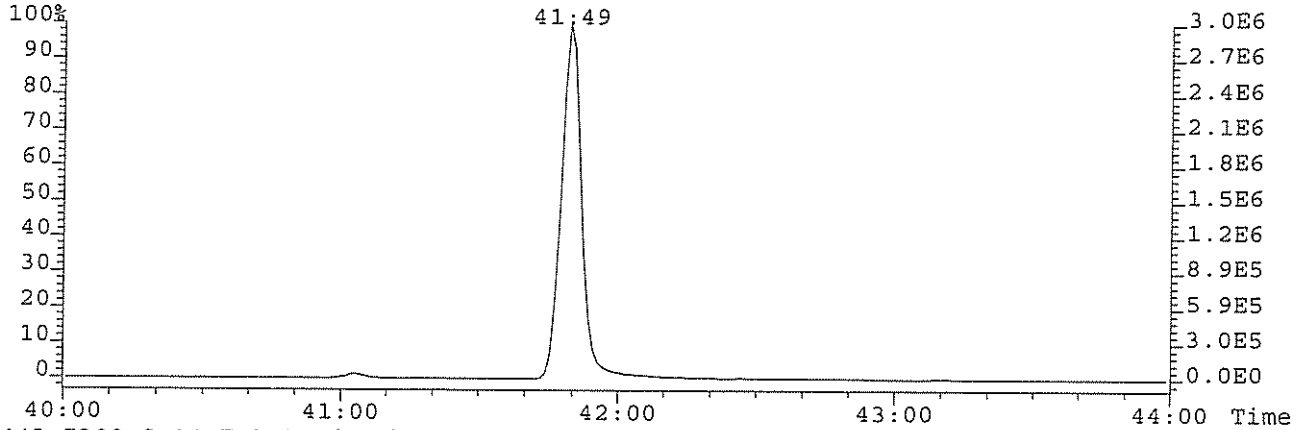
File:130711-2 #1-561 Acq:12-JUL-2013 05:36:30 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:RH-12ms(5-8,nP) Text:XE13 0952 3 Exp:RH-PD22  
423.7767 S:14 F:3 SMO(1,3)



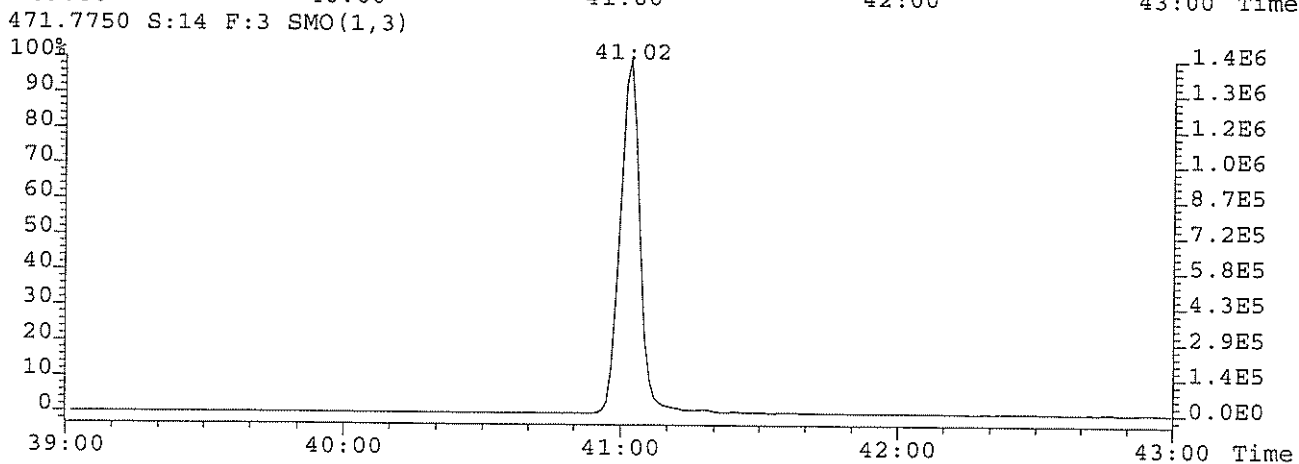
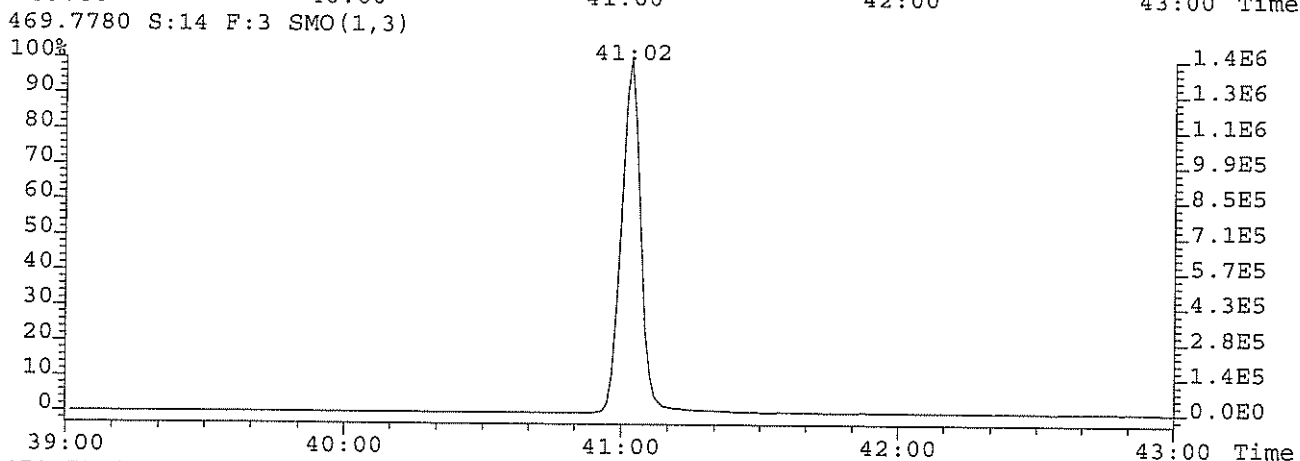
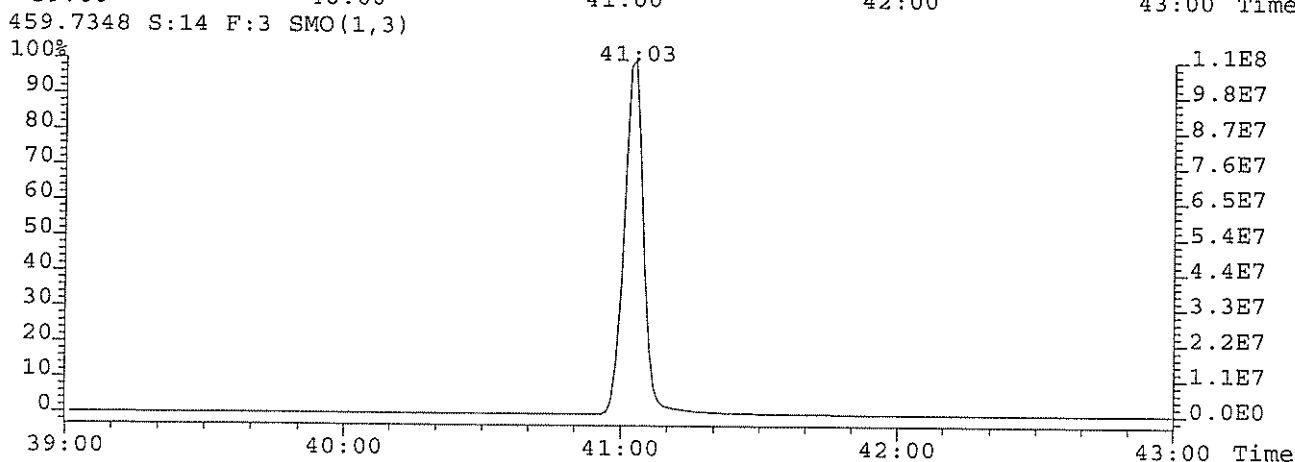
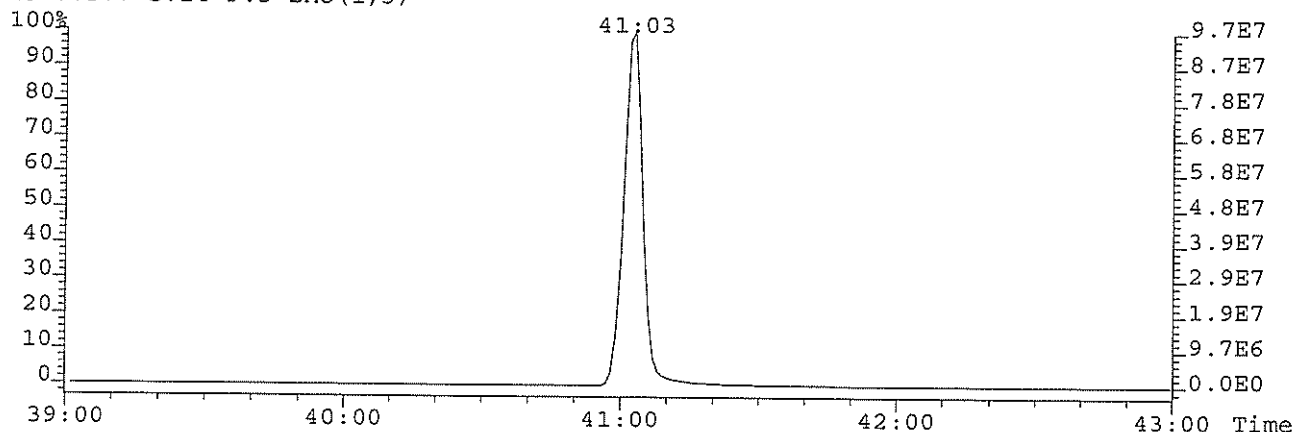
PCDDsクロマトグラム (10)  
(HpCDDs)



File:130711-2 #1-561 Acq:12-JUL-2013 05:36:30 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:RH-12ms(5-8,nP) Text:XE13 0952 3 Exp:RH-PD22  
441.7428 S:14 F:3 SMO(1,3)

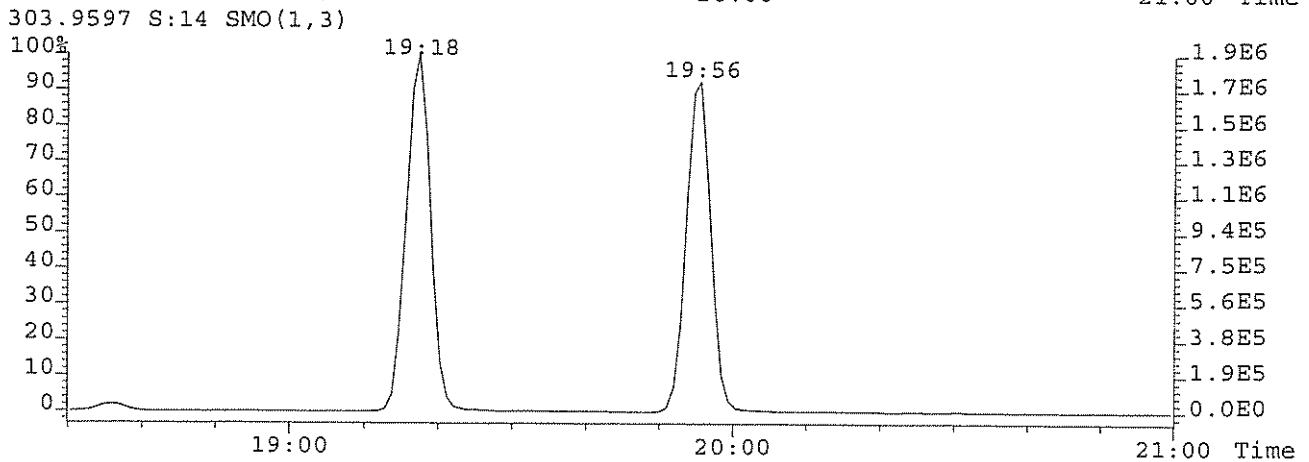
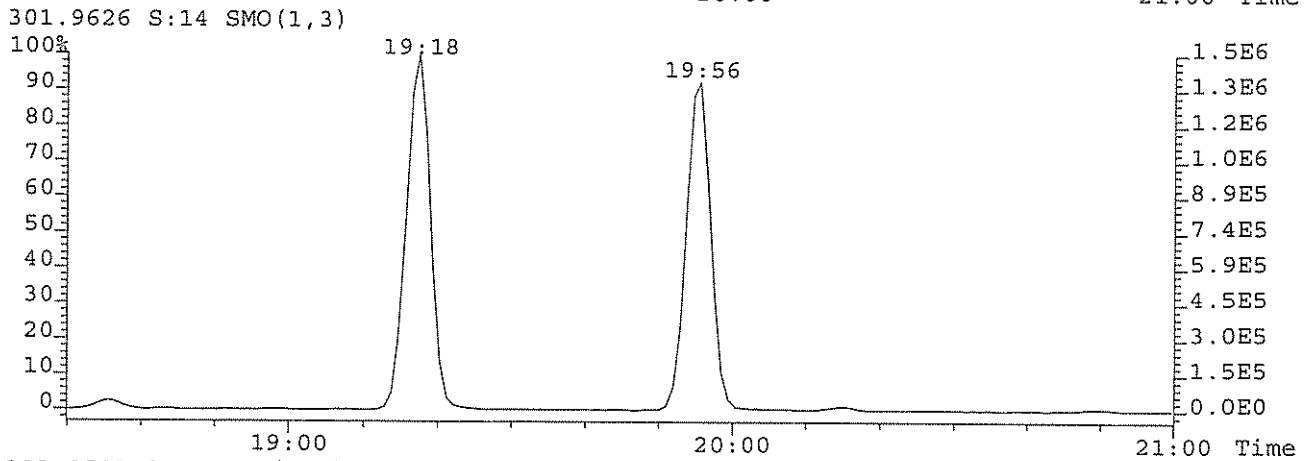
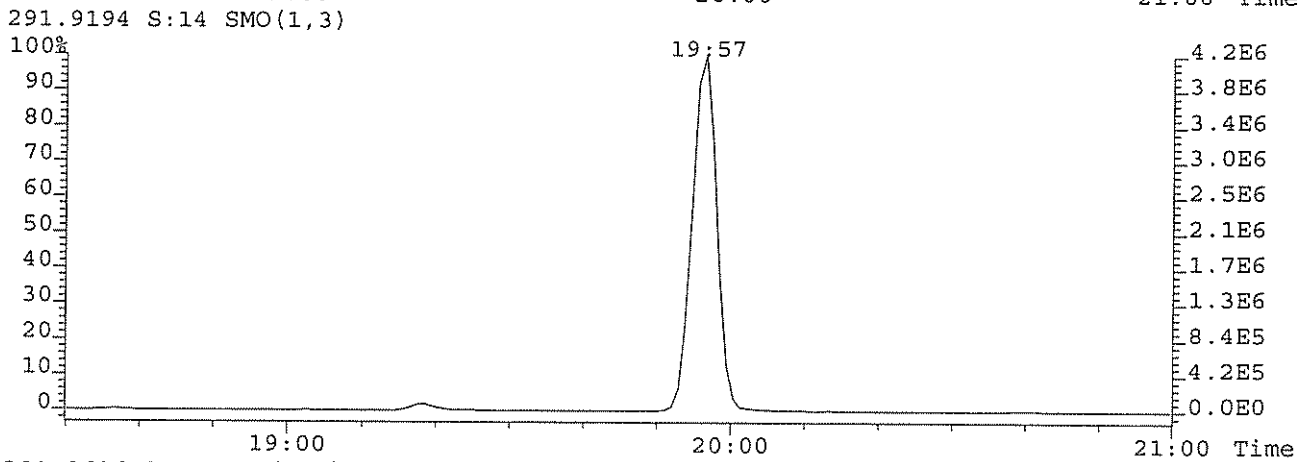
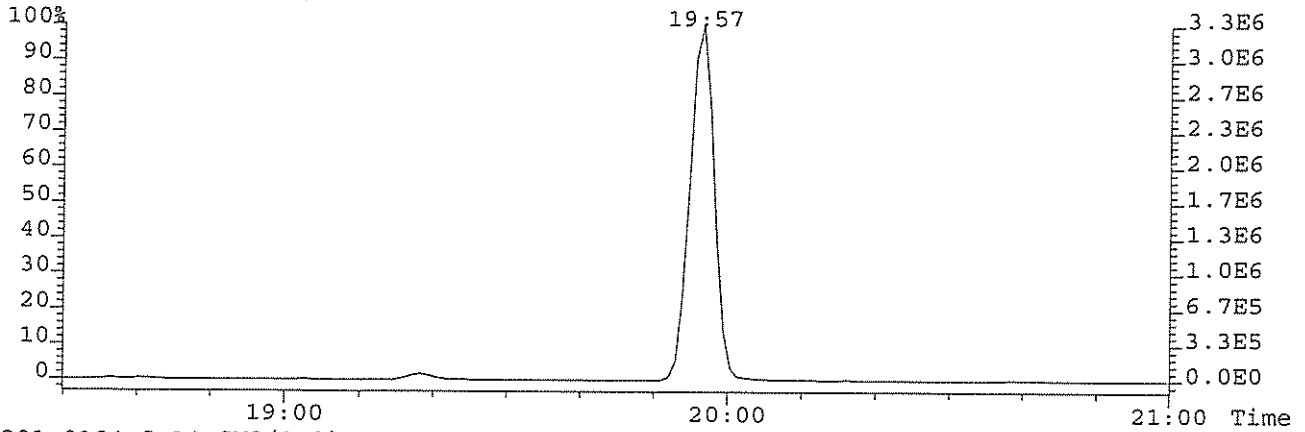


File:130711-2 #1-561 Acq:12-JUL-2013 05:36:30 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:RH-12ms(5-8,nP) Text:XE13 0952 3 Exp:RH-PD22



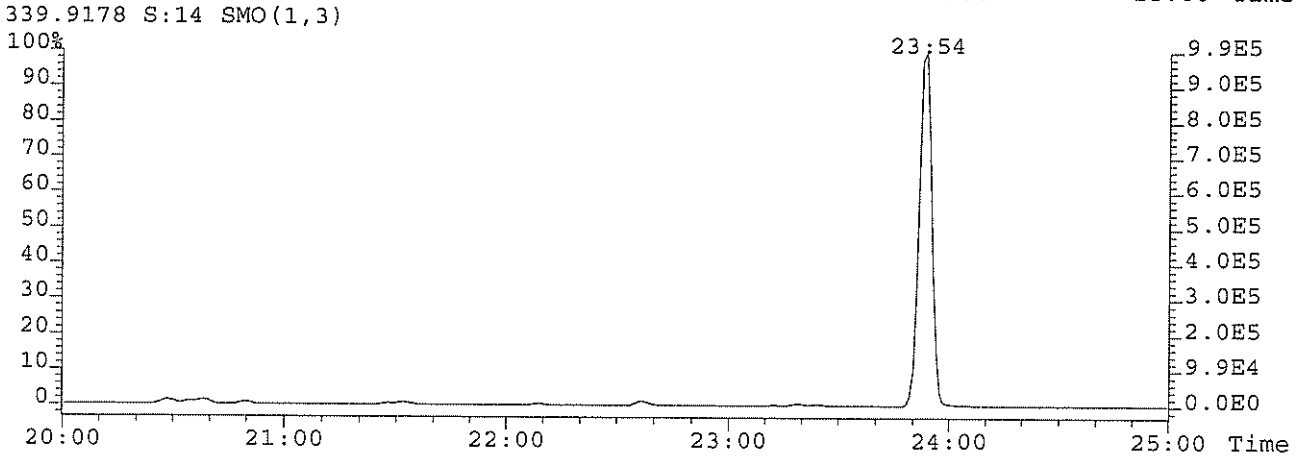
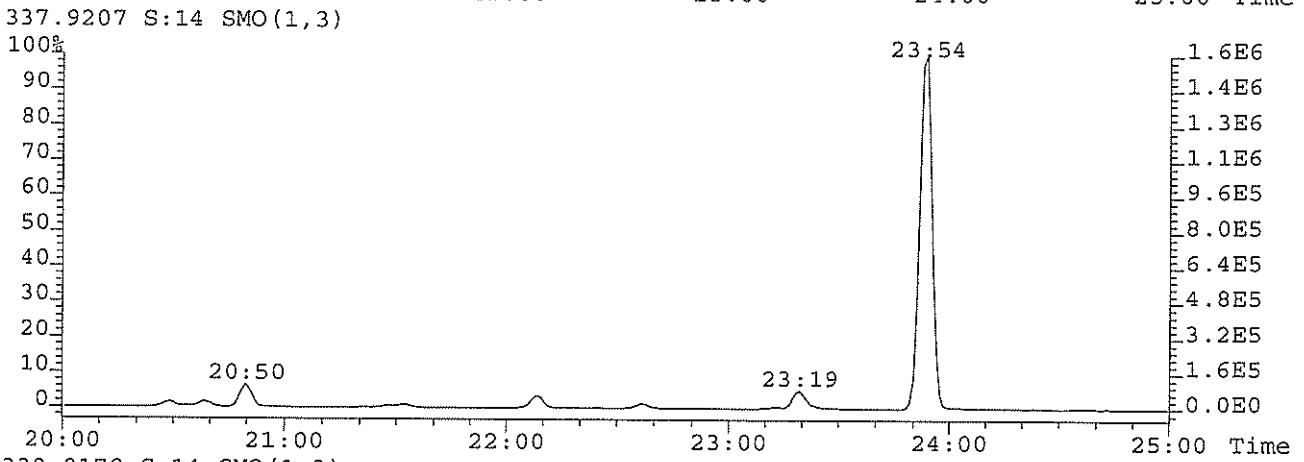
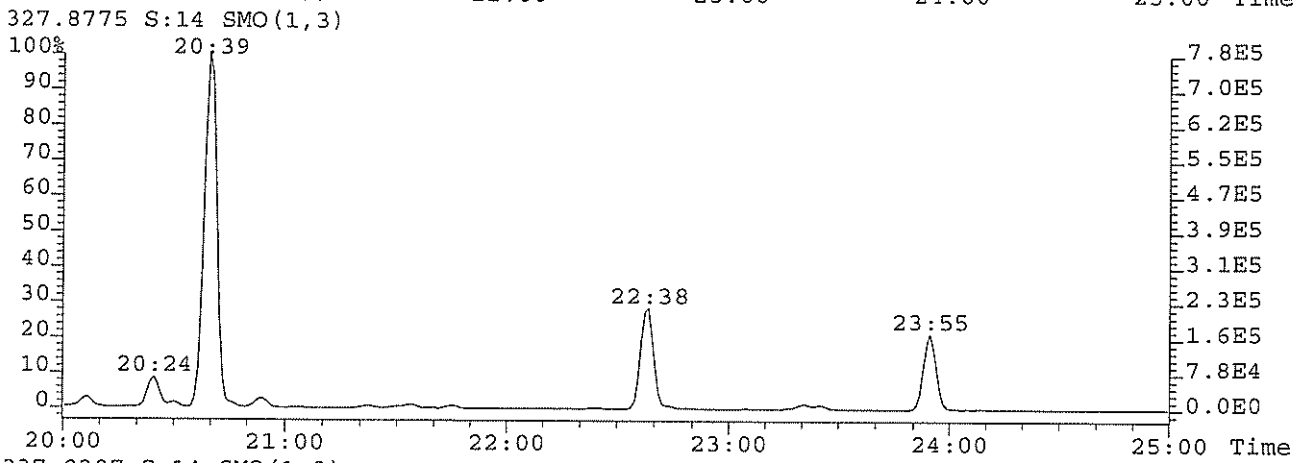
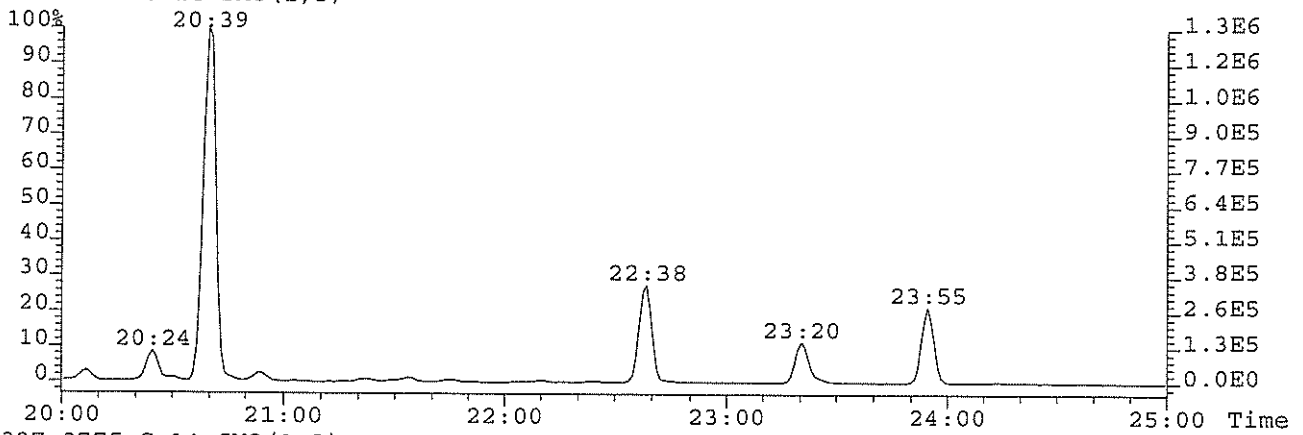
PCDDsクロマトグラム (12)  
(OCDD)

File:130711-2 #1-1430 Acq:12-JUL-2013 05:36:30 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:RH-12ms(5-8,nP) Text:XE13 0952 3 Exp:RH-PD22  
289.9224 S:14 SMO(1,3)



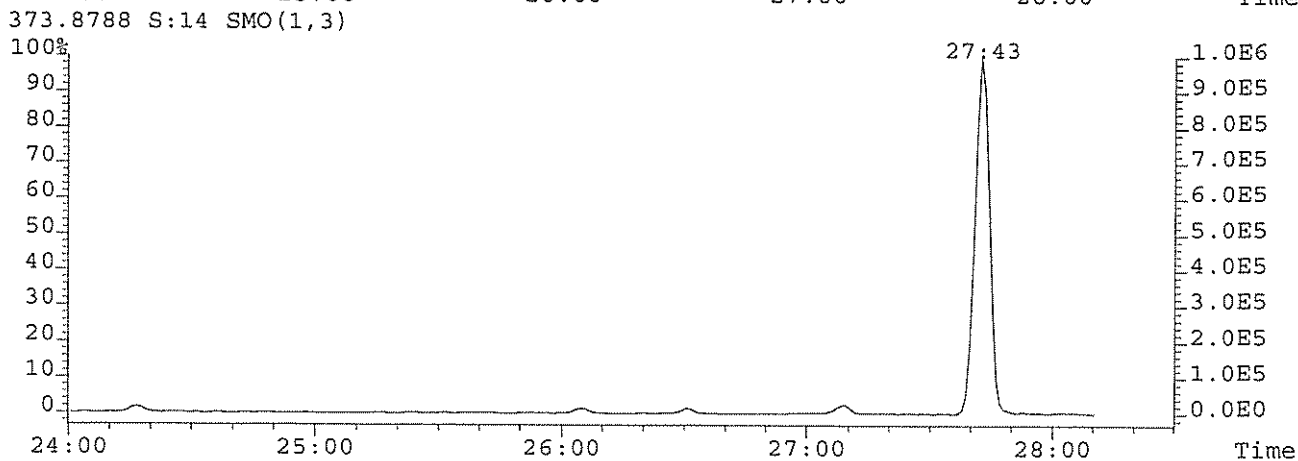
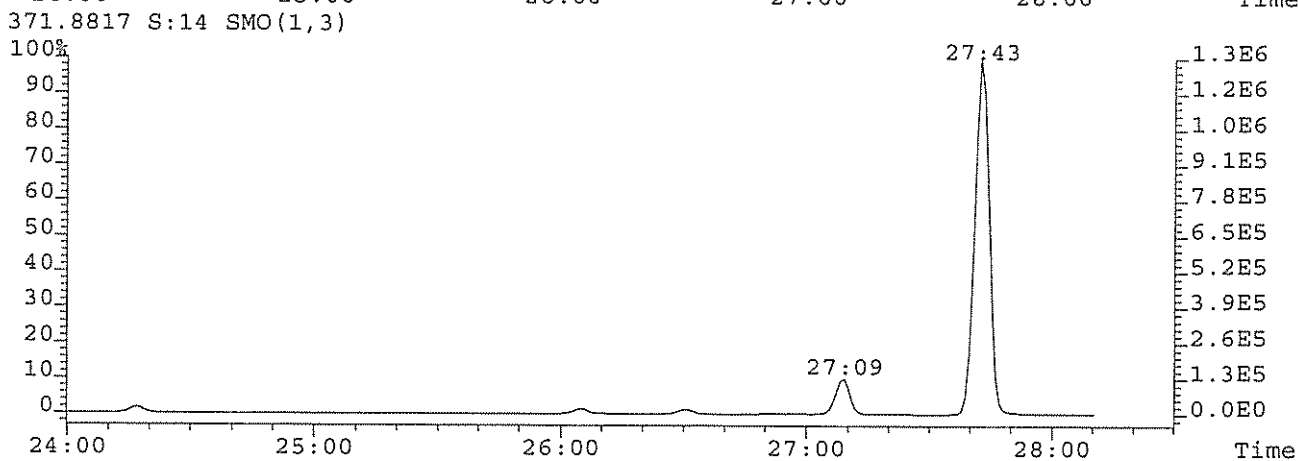
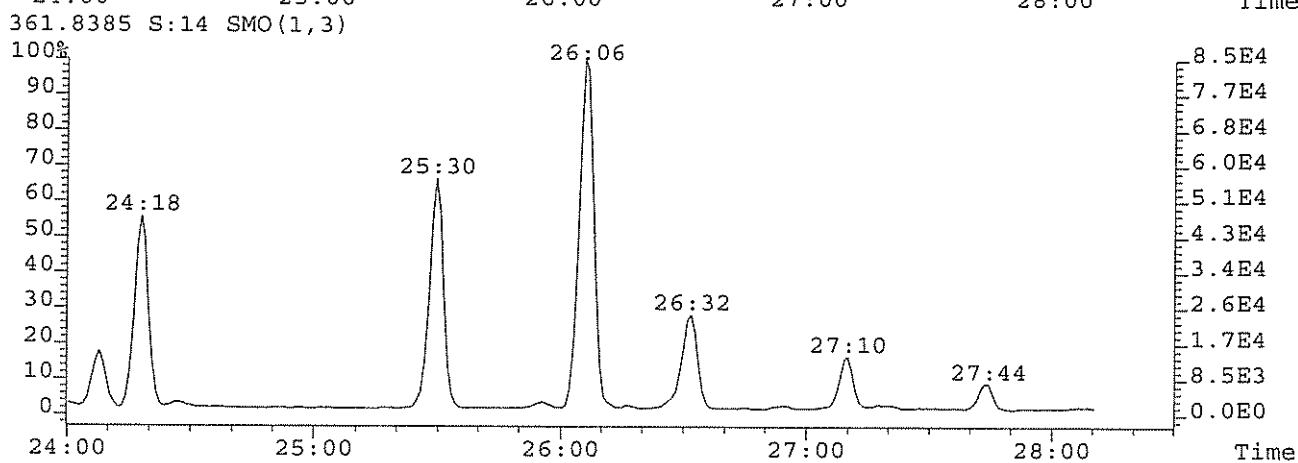
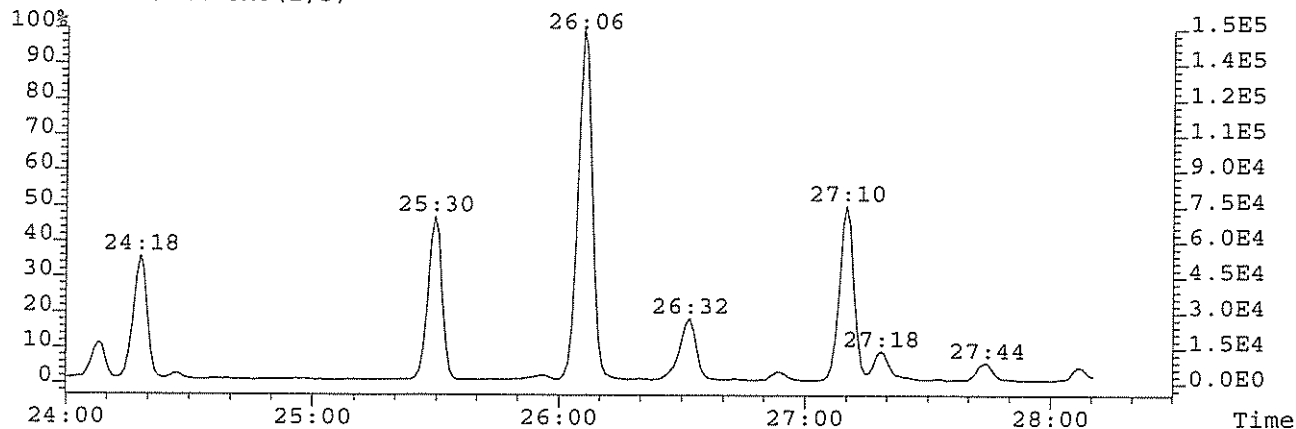
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 05:36:30 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:RH-12ms(5-8,nP) Text:XE13 0952 3 Exp:RH-PD22



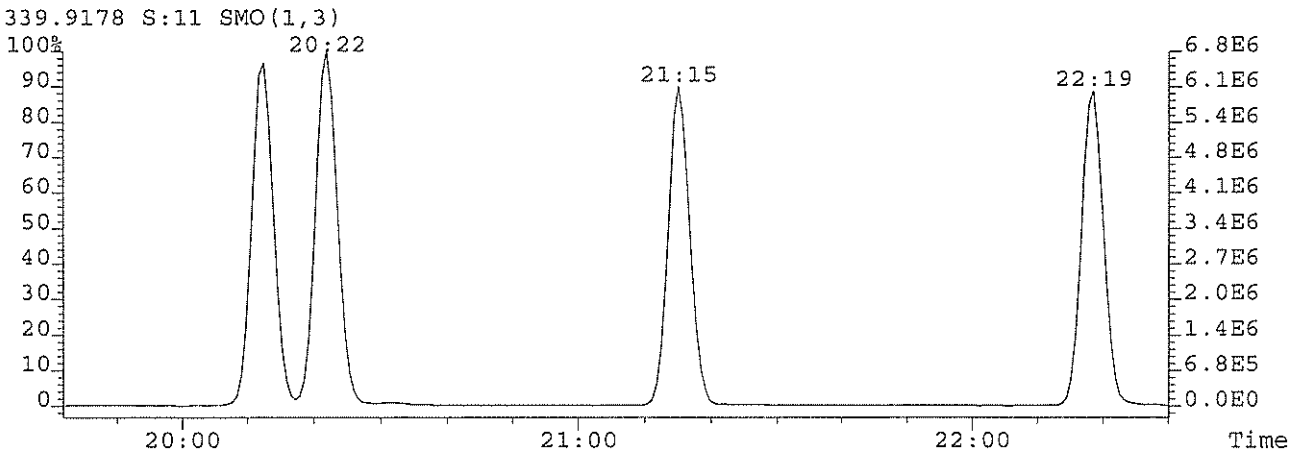
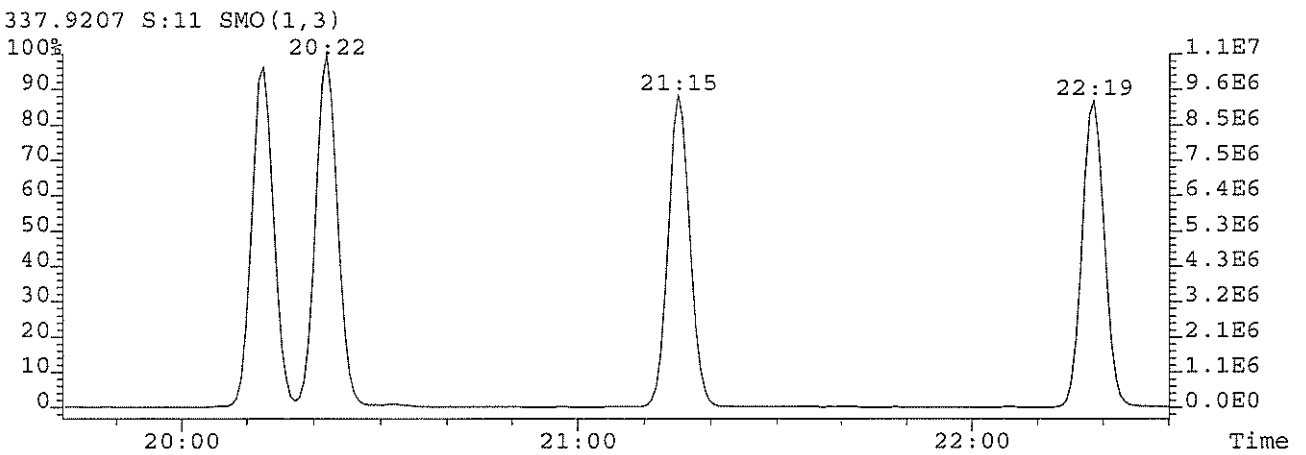
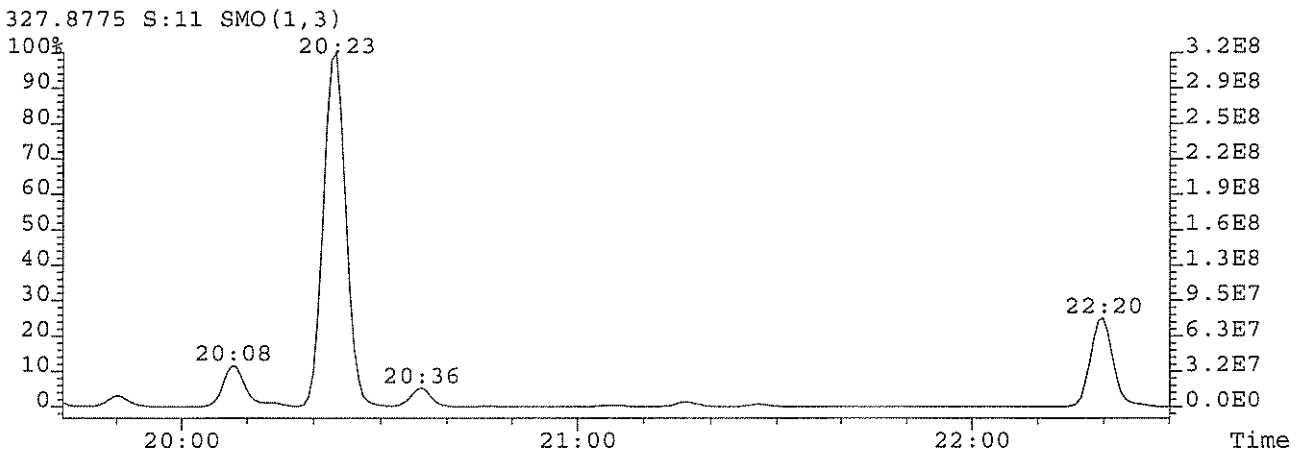
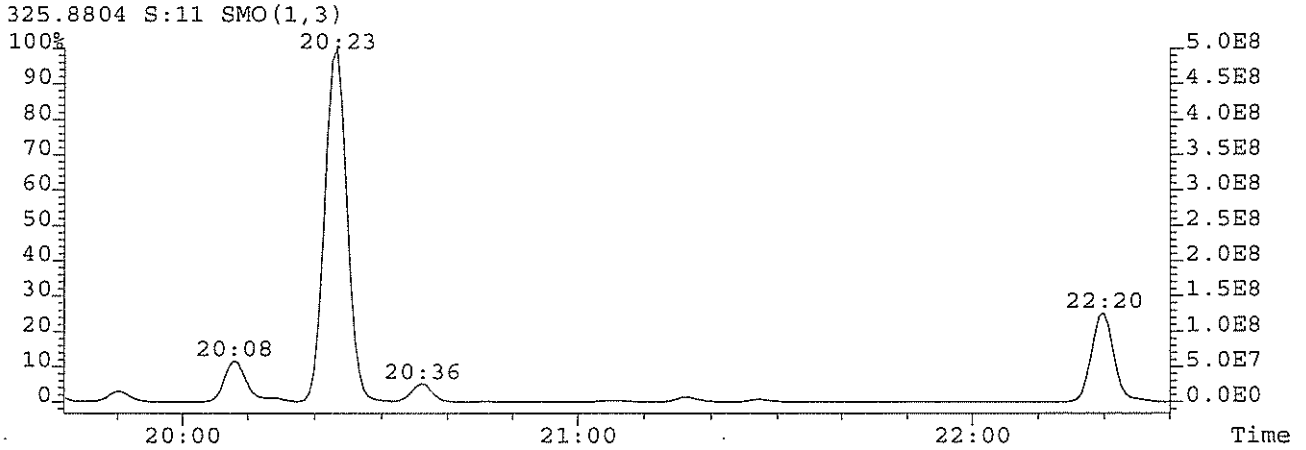
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 05:36:30 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:RH-12ms(5-8,nP) Text:XE13 0952 3 Exp:RH-PD22  
359.8415 S:14 SMO(1,3)



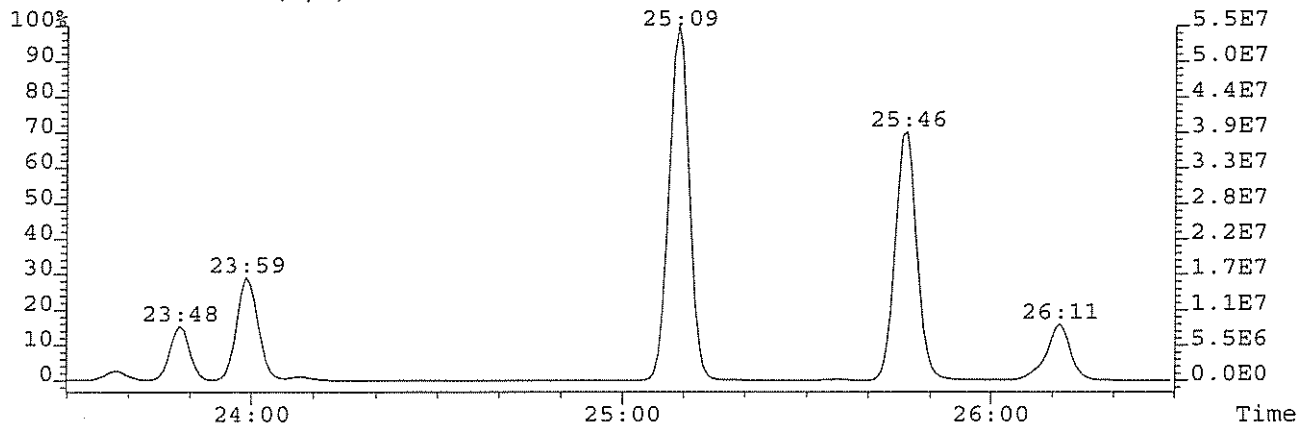
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130711-2 #1-2898 Acq:12-JUL-2013 00:55:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(mP) Text:XE13 0952 2 Exp:RH-MP11

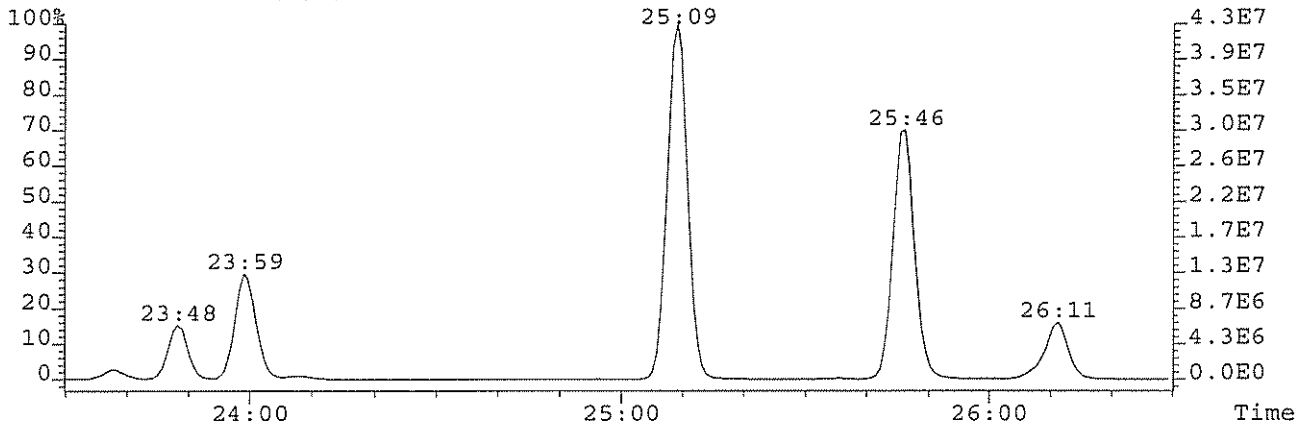


DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

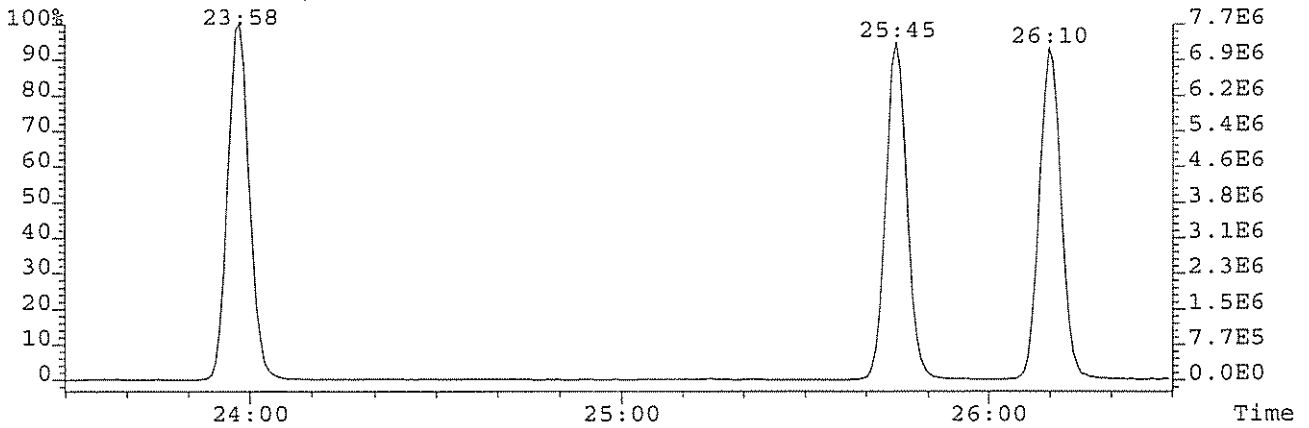
File:130711-2 #1-2898 Acq:12-JUL-2013 00:55:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(mP) Text:XE13 0952 2 Exp:RH-MP11  
359.8415 S:11 SMO(1,3)



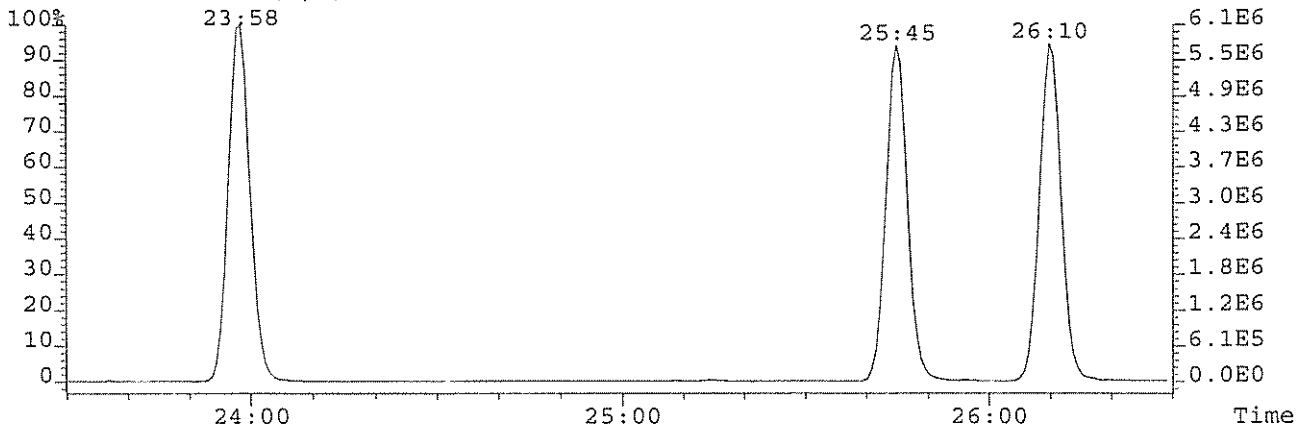
361.8385 S:11 SMO(1,3)



371.8817 S:11 SMO(1,3)

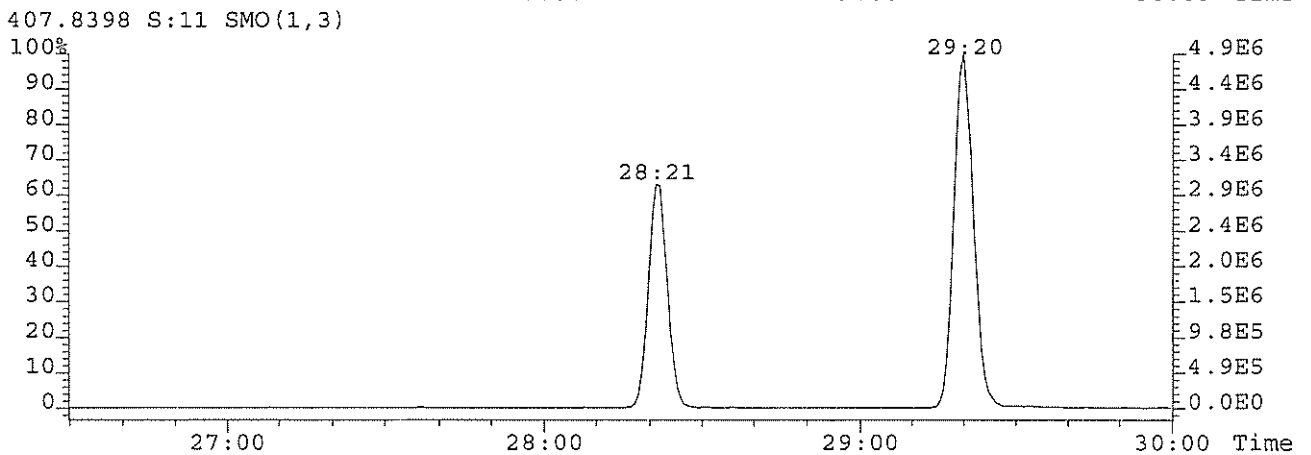
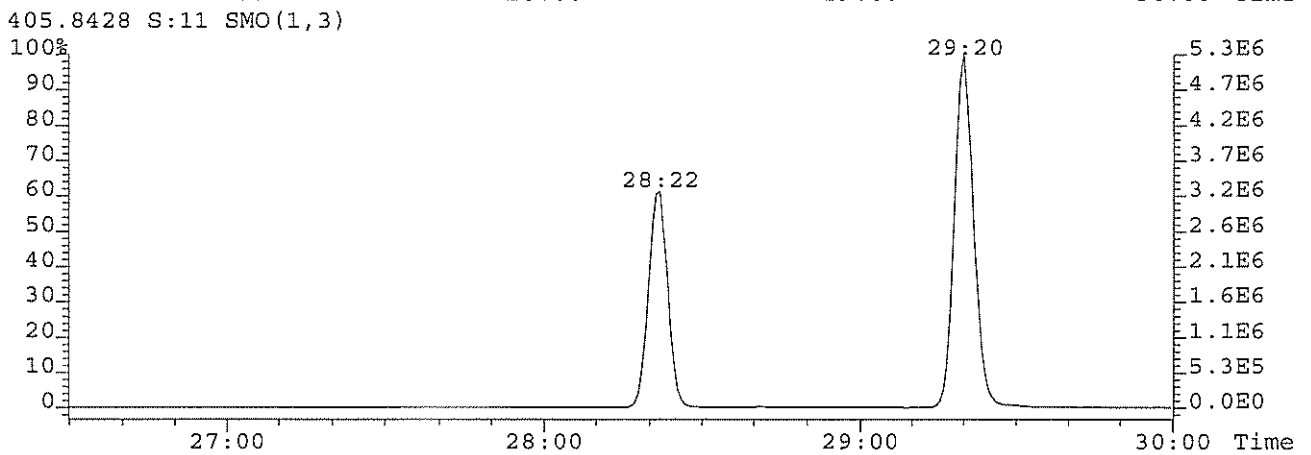
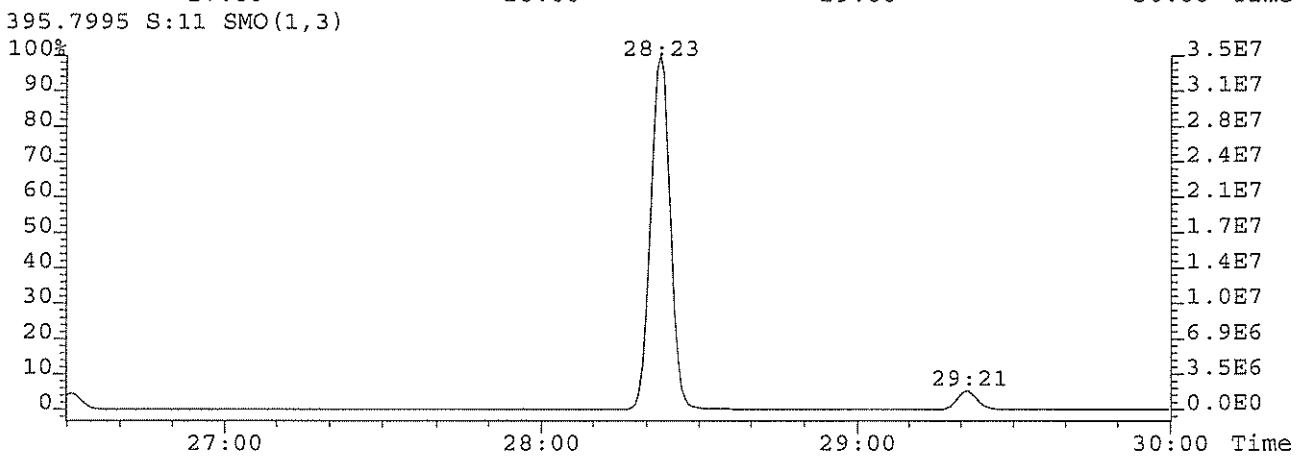
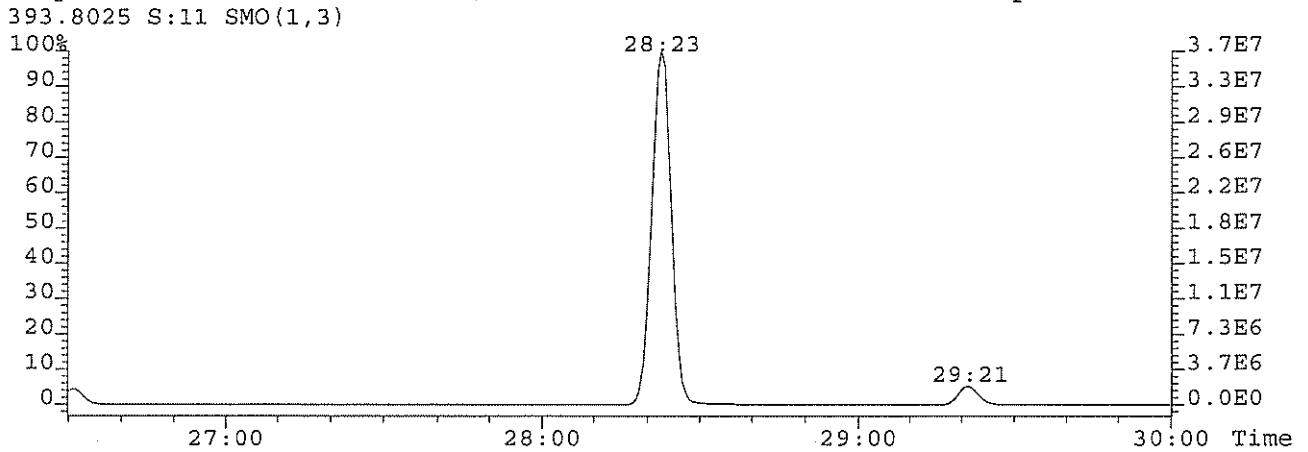


373.8788 S:11 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130711-2 #1-2898 Acq:12-JUL-2013 00:55:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(mP) Text:XE13 0952 2 Exp:RH-MP11



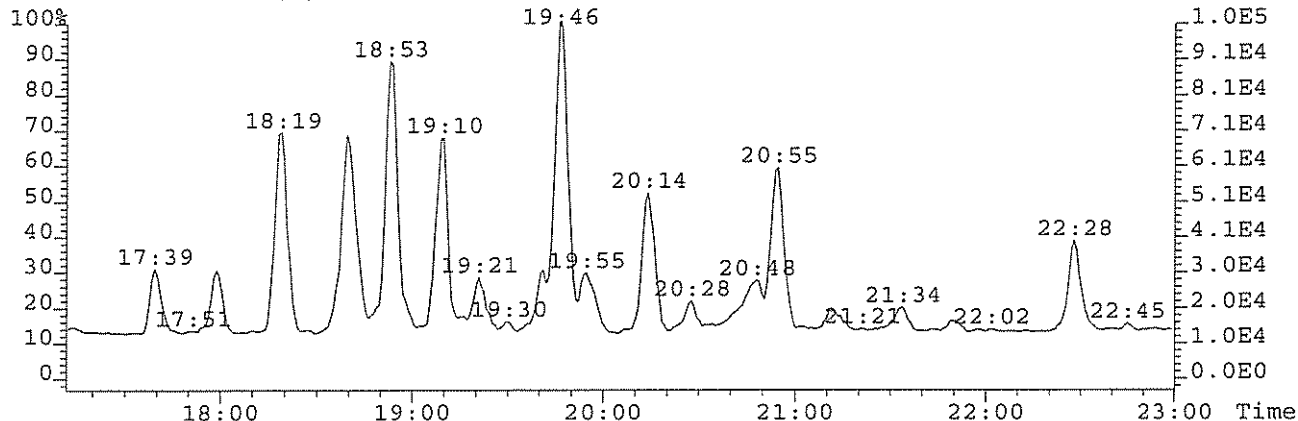
DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)



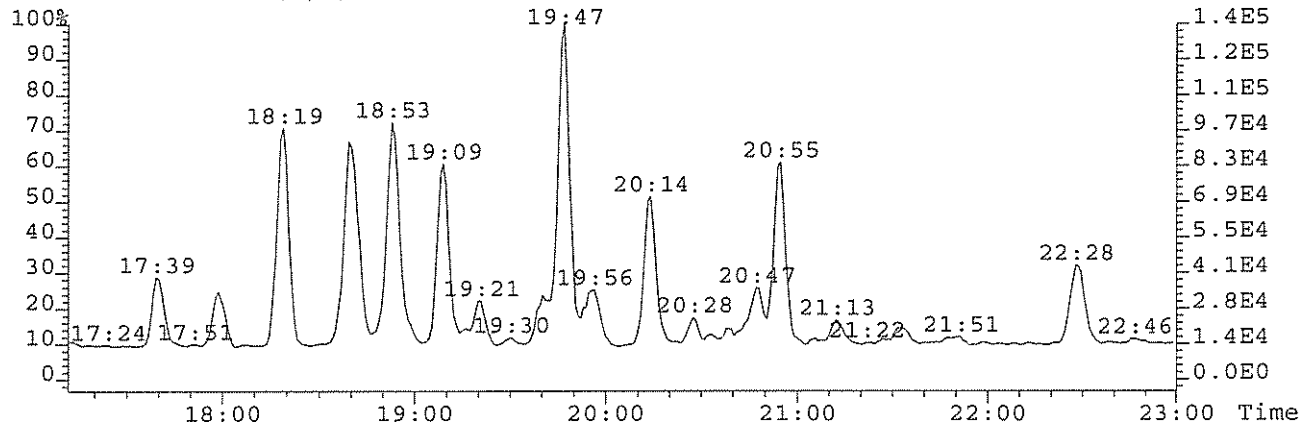
試料管理番号	XE 130953
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.7

File:130712-2 #1-1578 Acq:12-JUL-2013 23:56:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:BPX-DXN(4-6DXN) Text:XE13 0953 Exp:BPX04

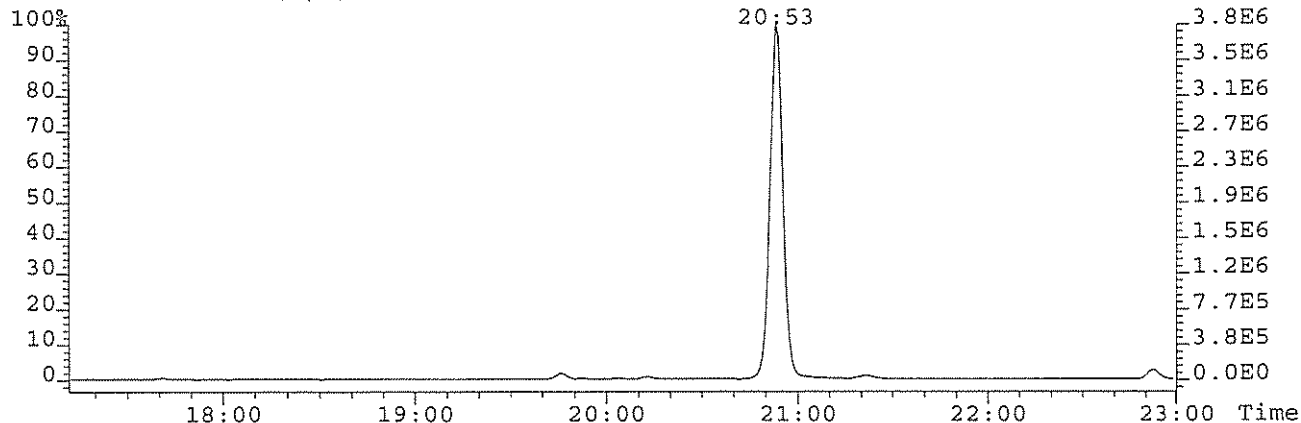
303.9016 S:10 SMO(1,3)



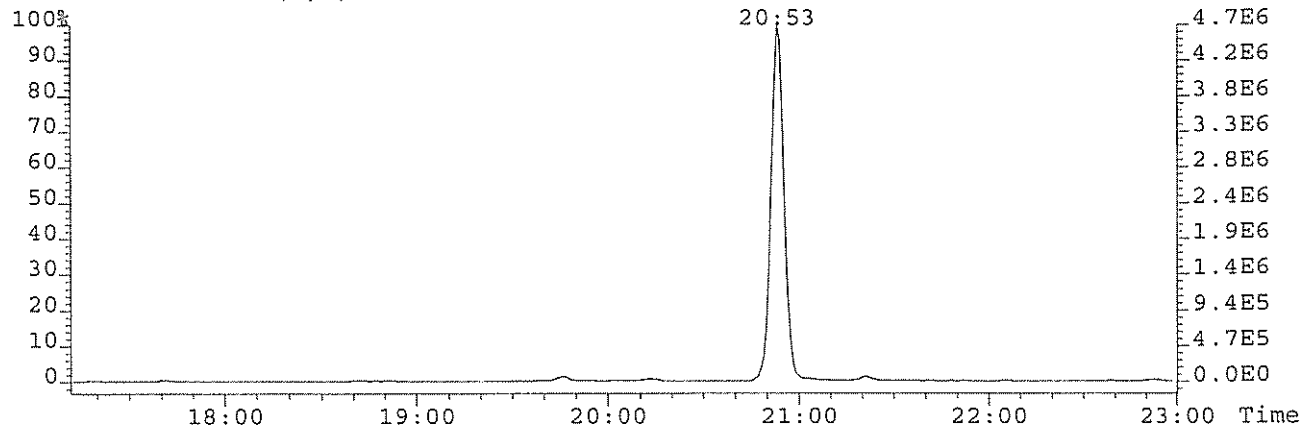
305.8987 S:10 SMO(1,3)



315.9419 S:10 SMO(1,3)

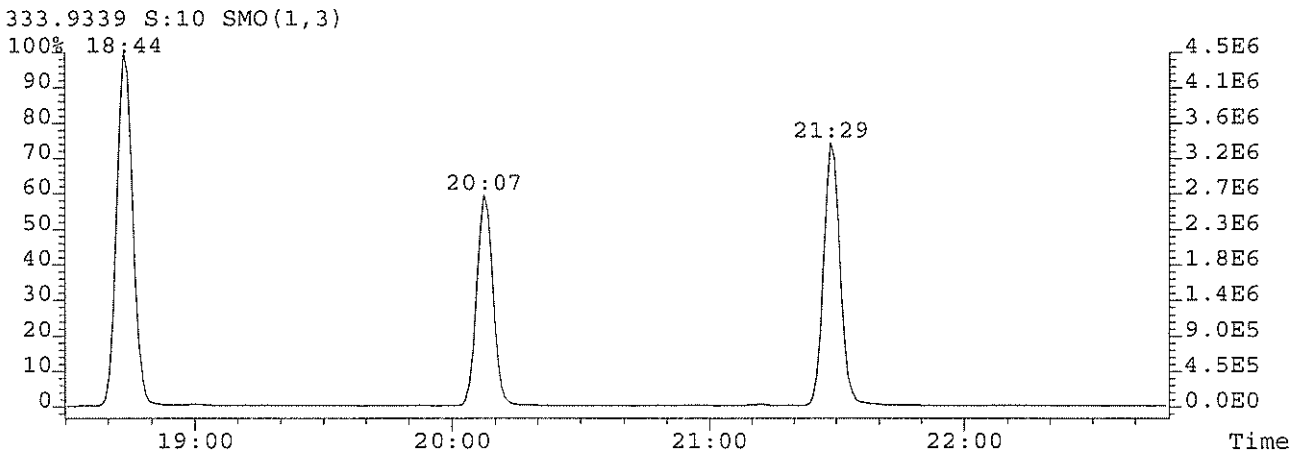
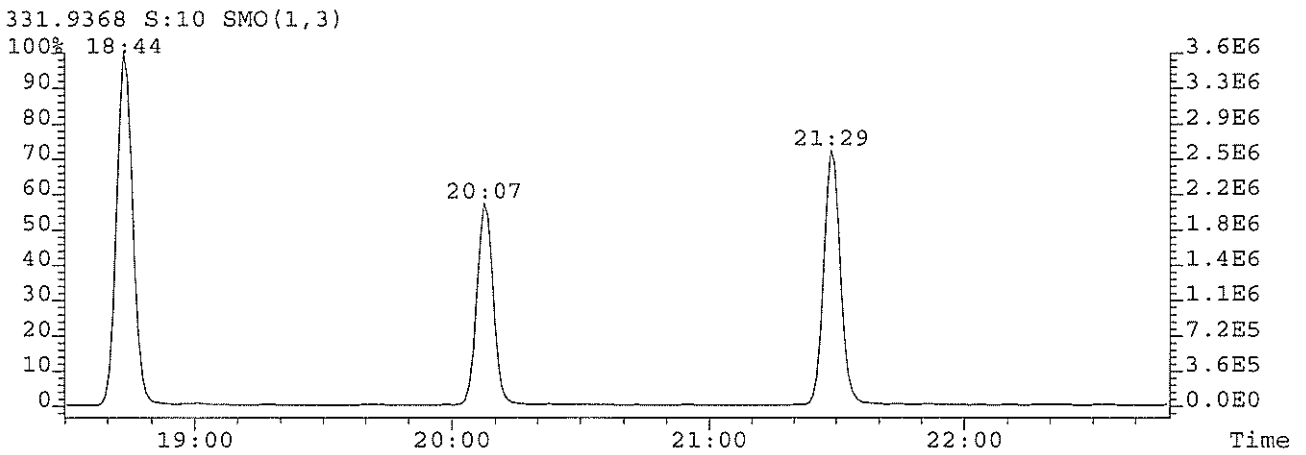
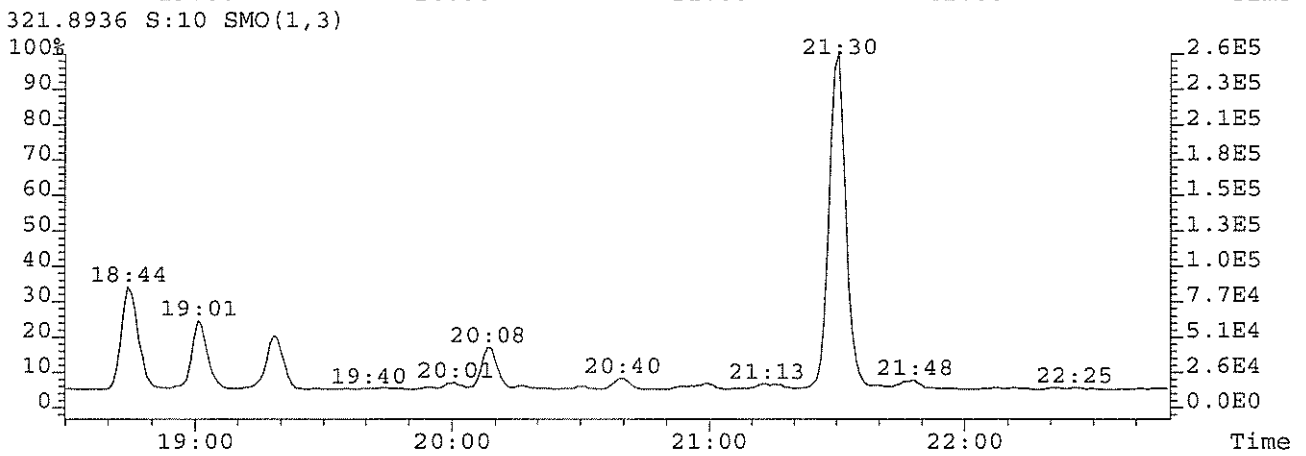
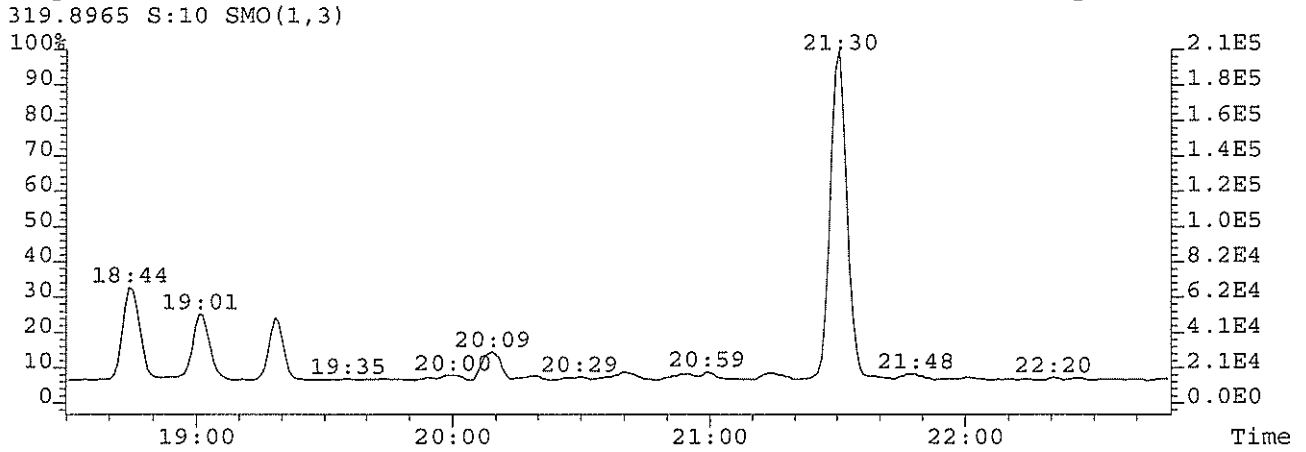


317.9389 S:10 SMO(1,3)



PCDFsクロマトグラム (1)  
(TeCDFs)

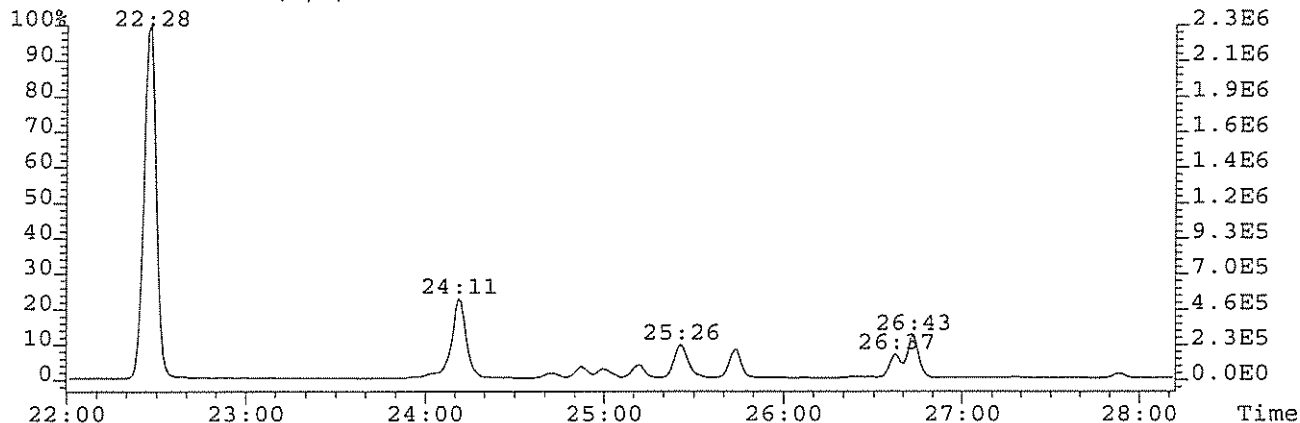
File:130712-2 #1-1578 Acq:12-JUL-2013 23:56:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:BPX-DXN(4-6DXN) Text:XE13 0953 Exp:BPX04



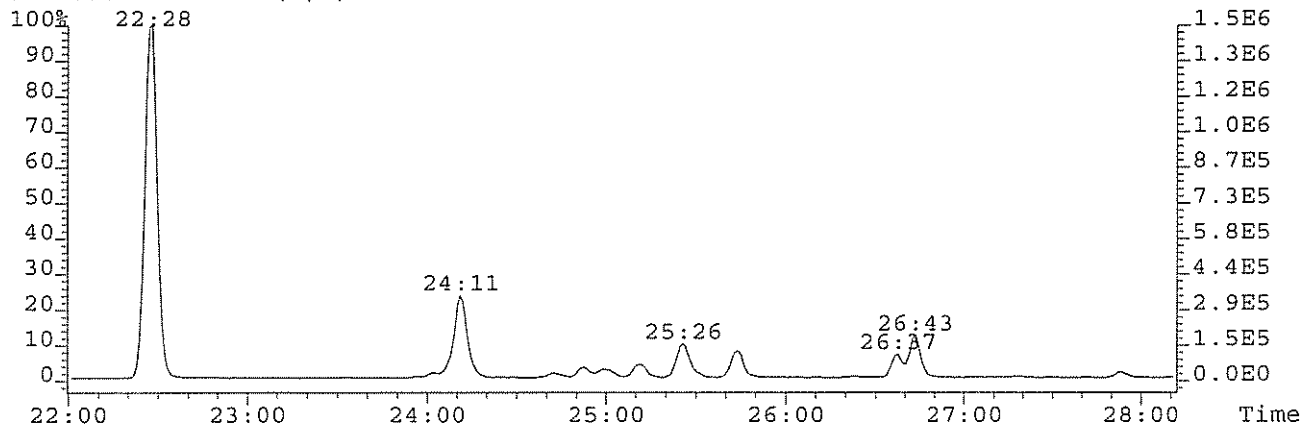
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130712-2 #1-1578 Acq:12-JUL-2013 23:56:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:BPX-DXN(4-6DXN) Text:XE13 0953 Exp:BPX04

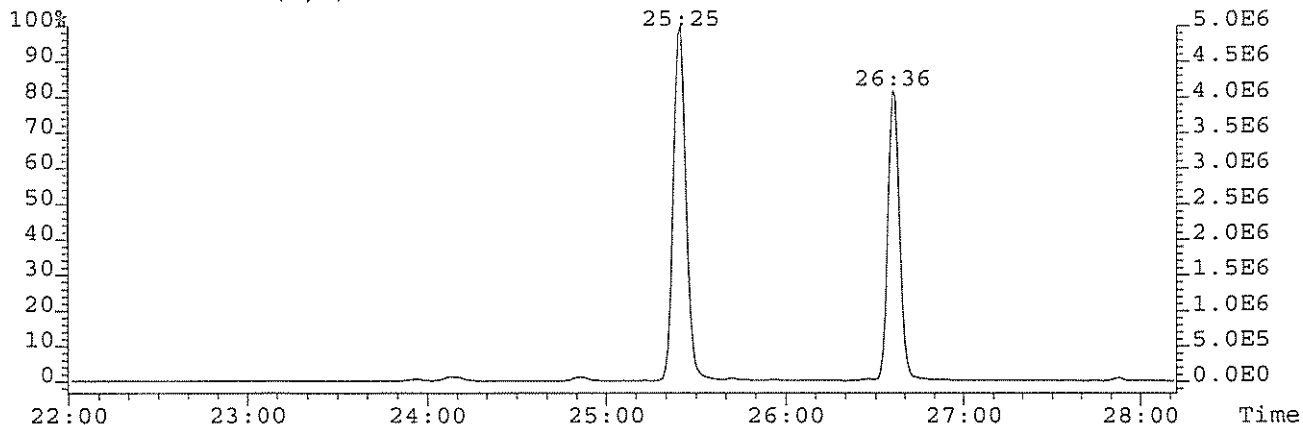
339.8597 S:10 SMO(1,3)



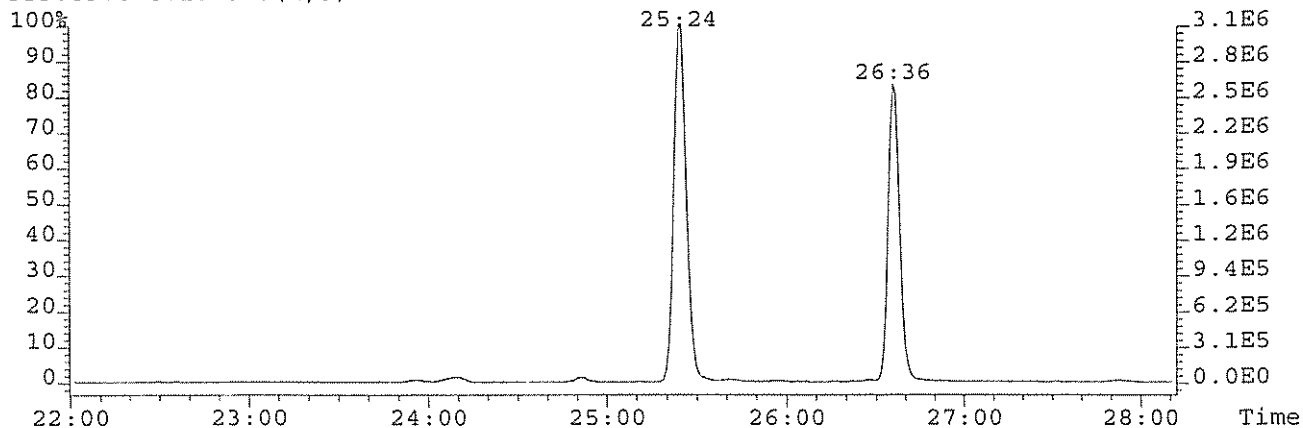
341.8568 S:10 SMO(1,3)



351.9000 S:10 SMO(1,3)

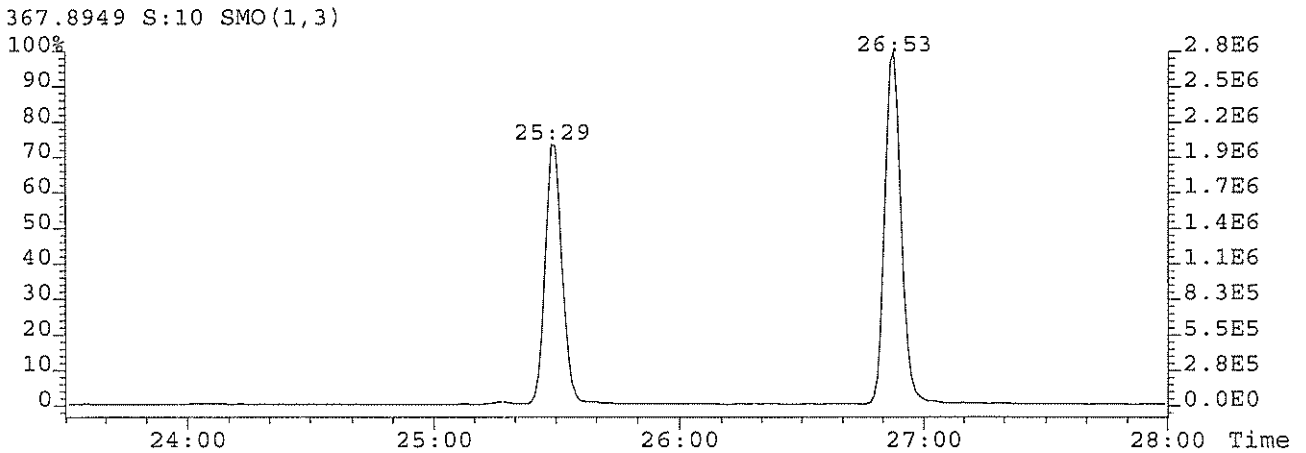
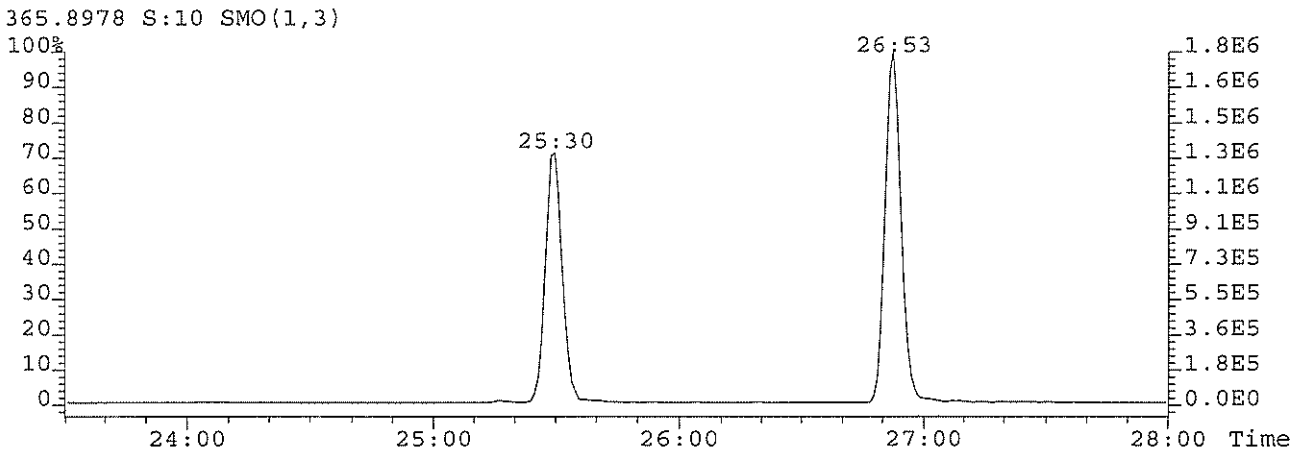
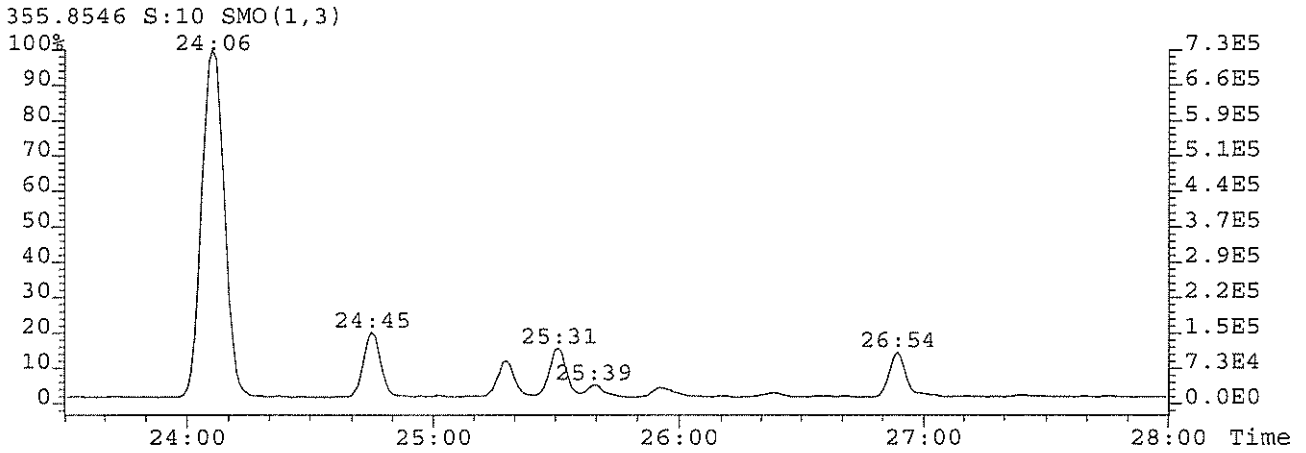
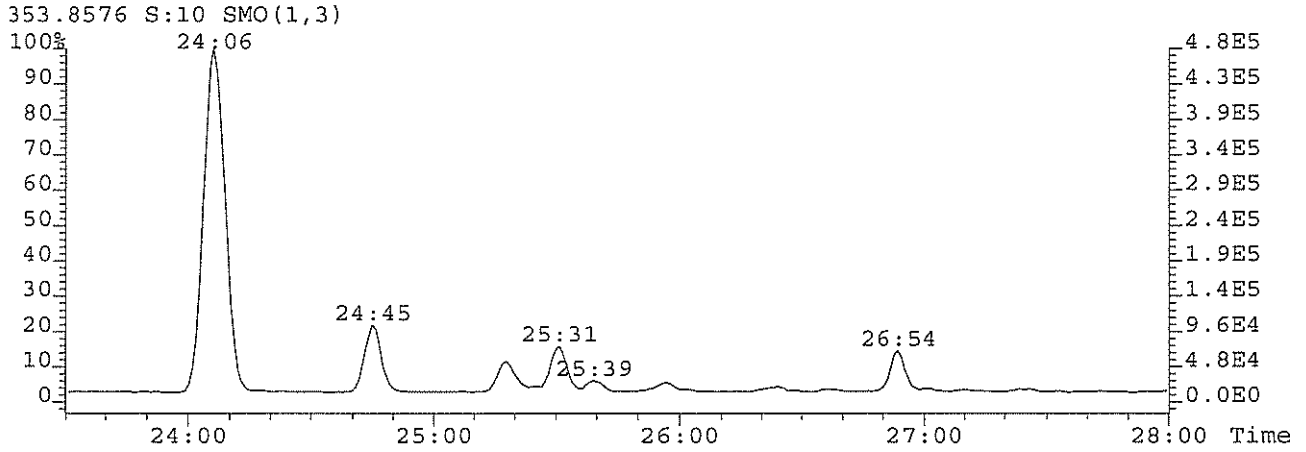


353.8970 S:10 SMO(1,3)



PCDFsクロマトグラム (3)  
(PeCDFs)

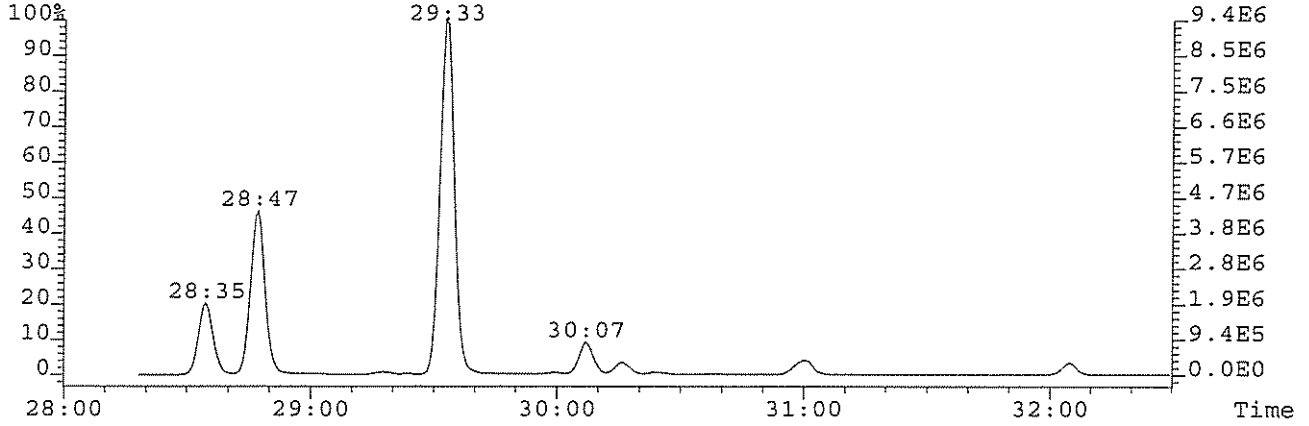
File:130712-2 #1-1578 Acq:12-JUL-2013 23:56:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:BPX-DXN(4-6DXN) Text:XE13 0953 Exp:BPX04



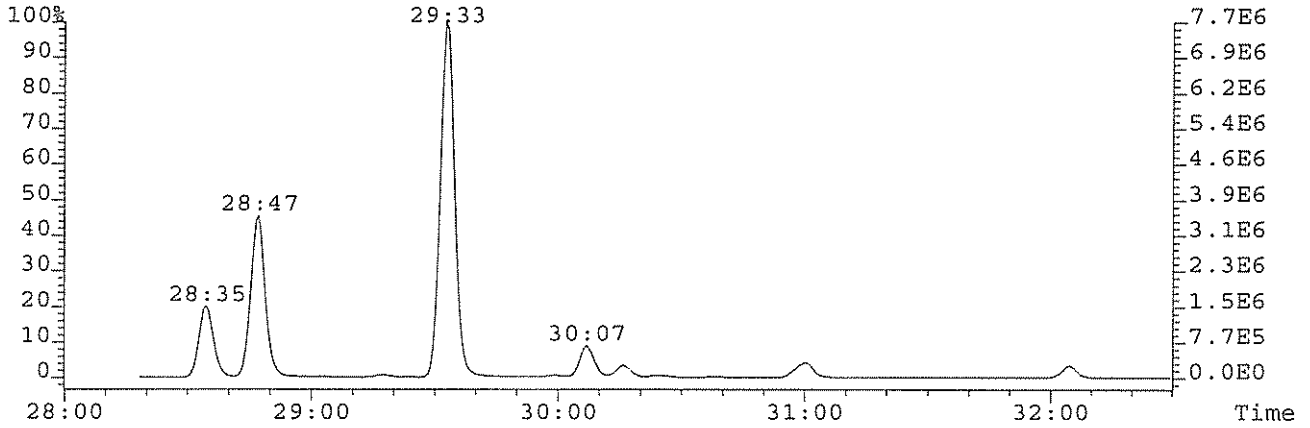
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130712-2 #1-1118 Acq:12-JUL-2013 23:56:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:BPX-DXN(4-6DXN) Text:XE13 0953 Exp:BPX04

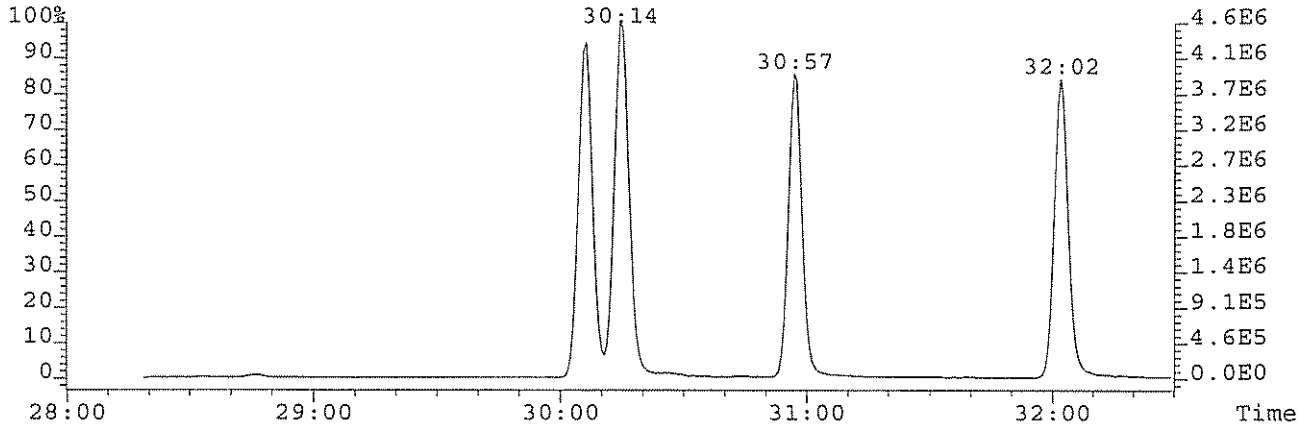
373.8207 S:10 F:2 SMO(1,3)



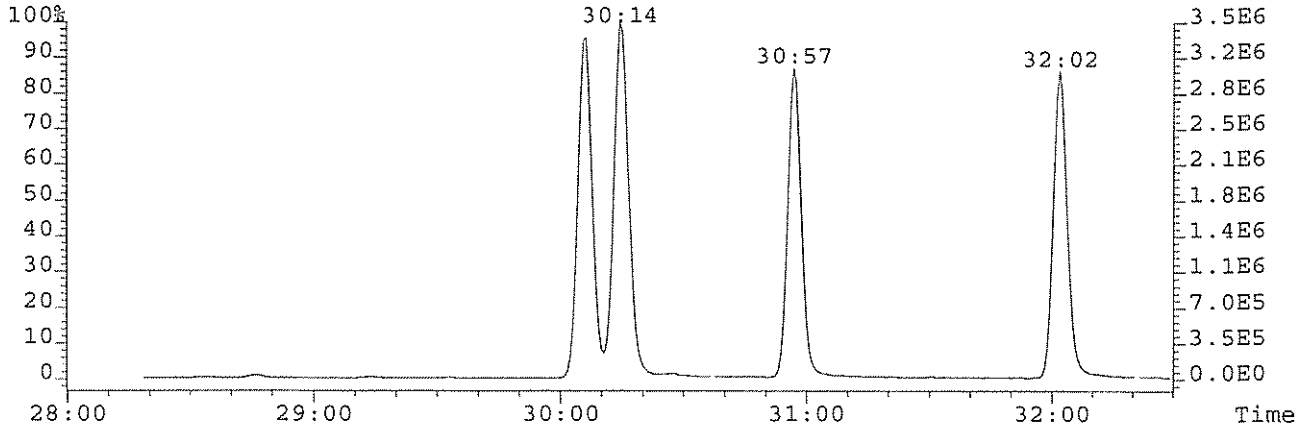
375.8178 S:10 F:2 SMO(1,3)



385.8610 S:10 F:2 SMO(1,3)



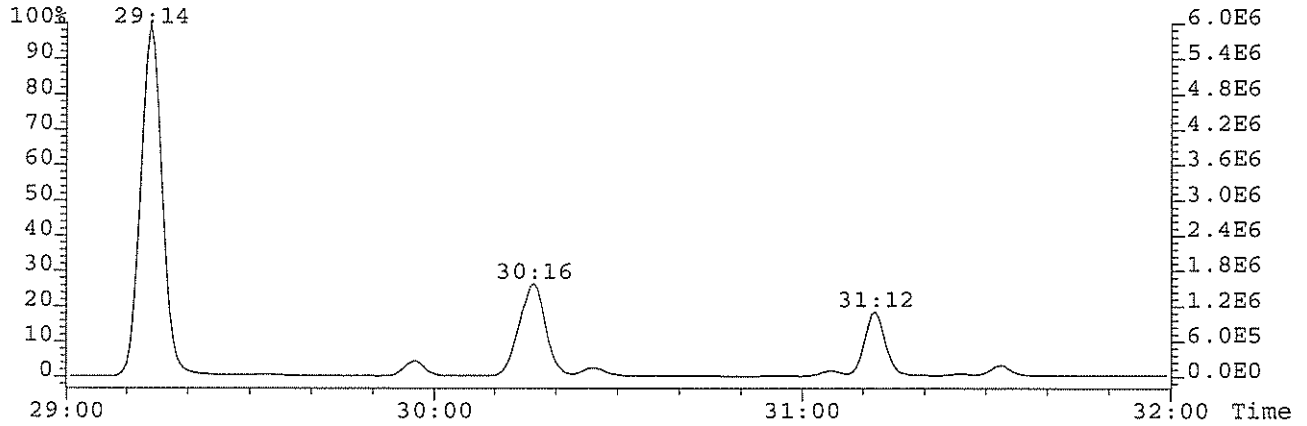
387.8580 S:10 F:2 SMO(1,3)



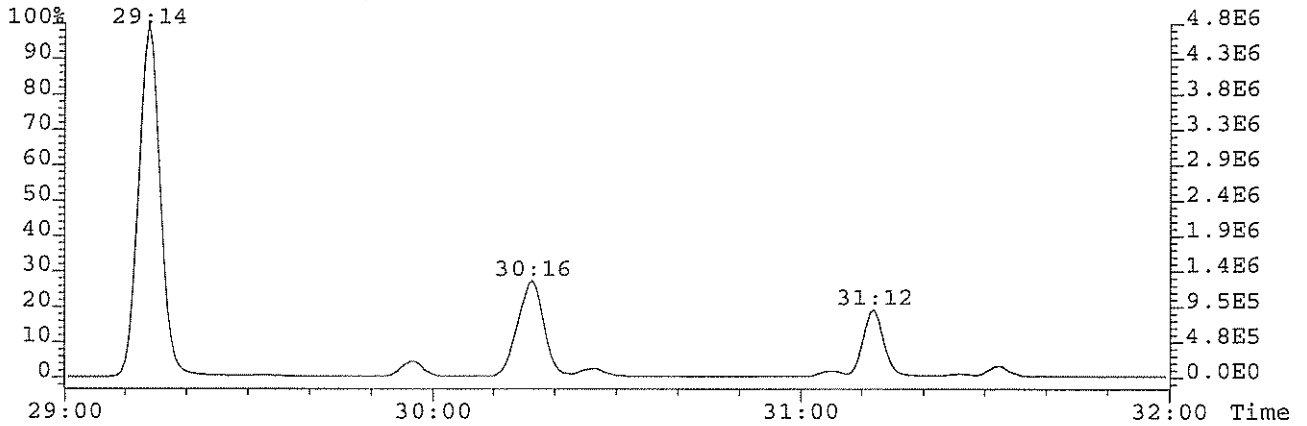
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1118 Acq:12-JUL-2013 23:56:41 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:BPX-DXN(4-6DXN) Text:XE13 0953 Exp:BPX04

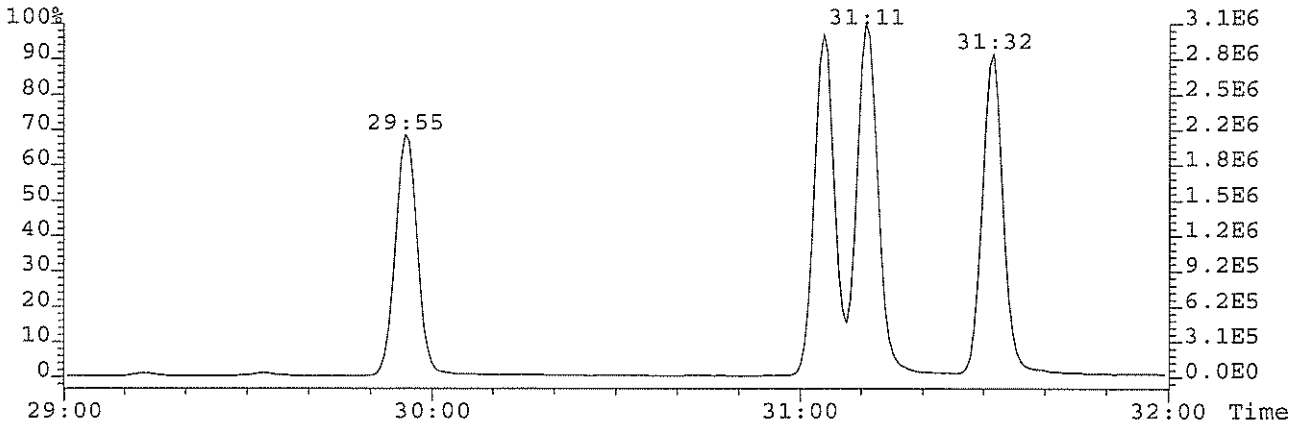
389.8156 S:10 F:2 SMO(1,3)



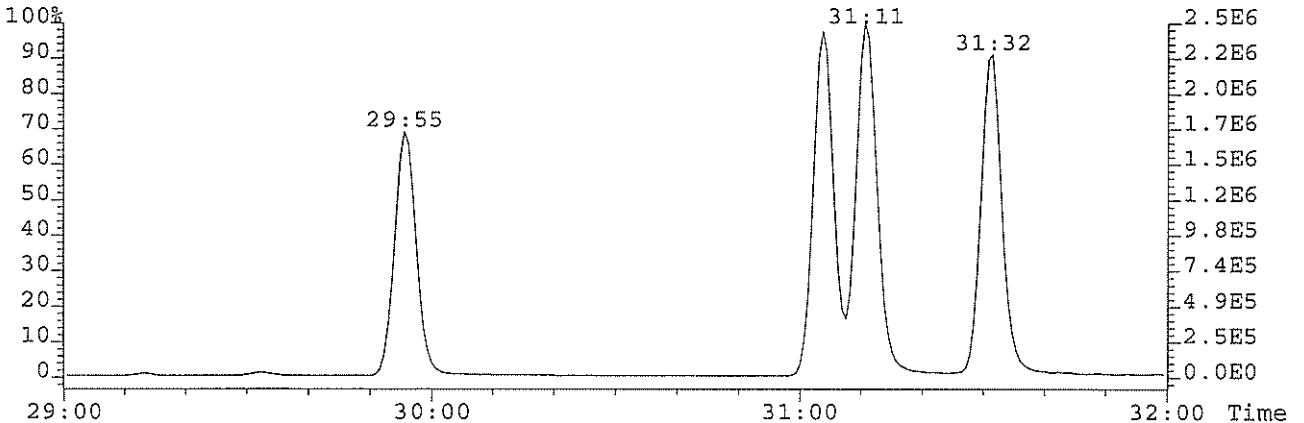
391.8127 S:10 F:2 SMO(1,3)



401.8559 S:10 F:2 SMO(1,3)

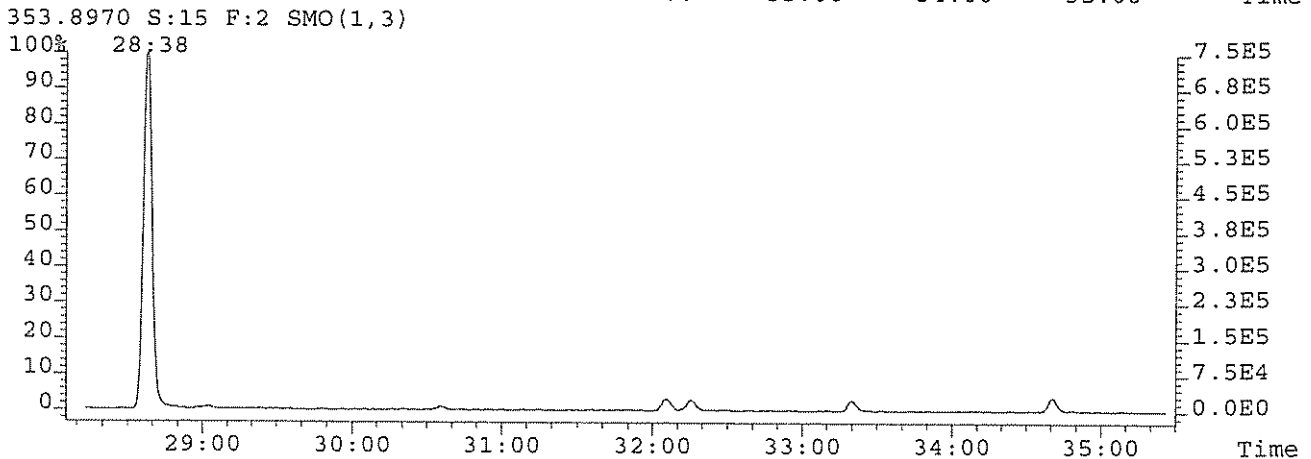
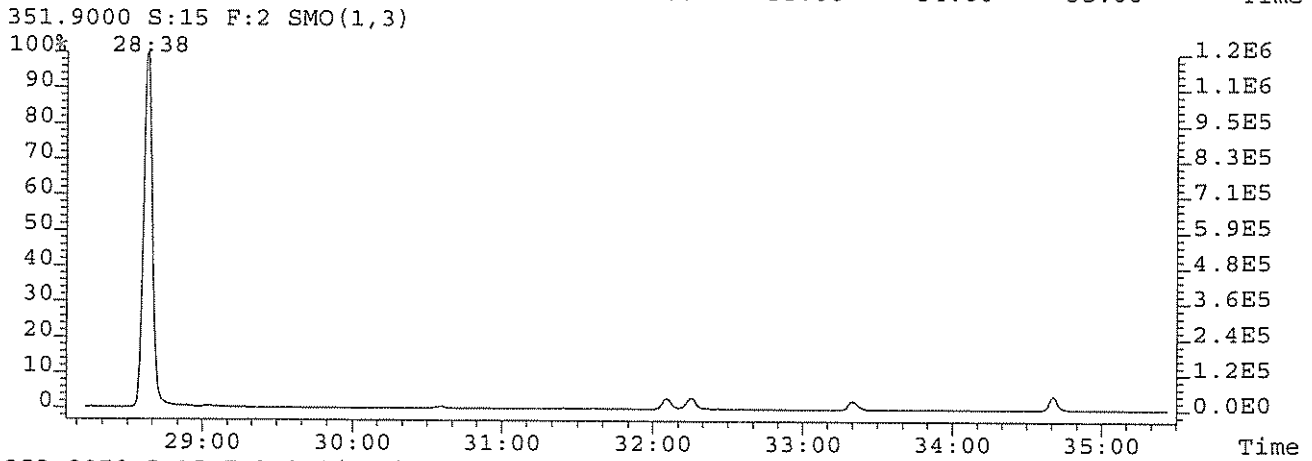
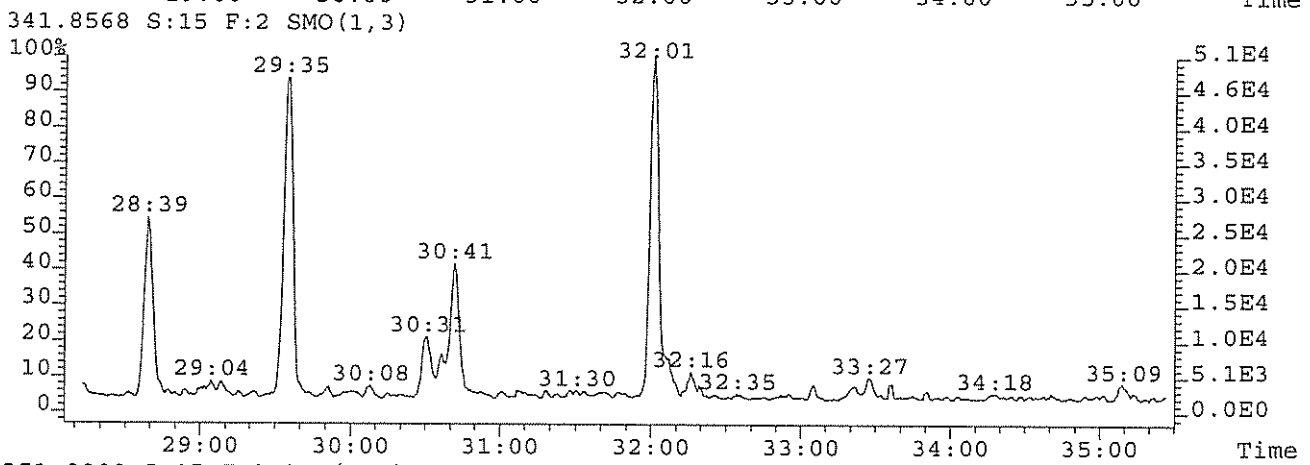
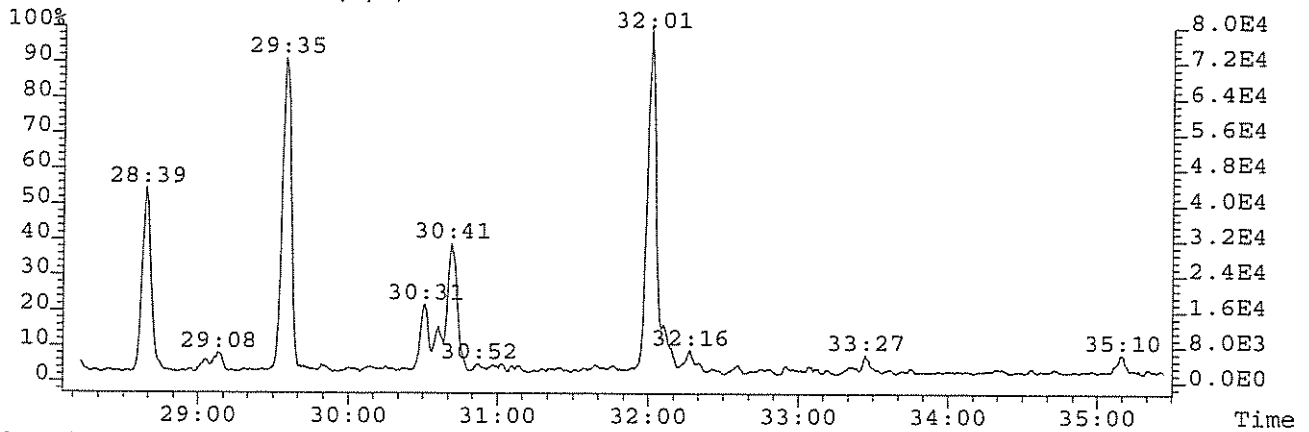


403.8530 S:10 F:2 SMO(1,3)



PCDDsクロマトグラム (6)  
(HxCDDs)

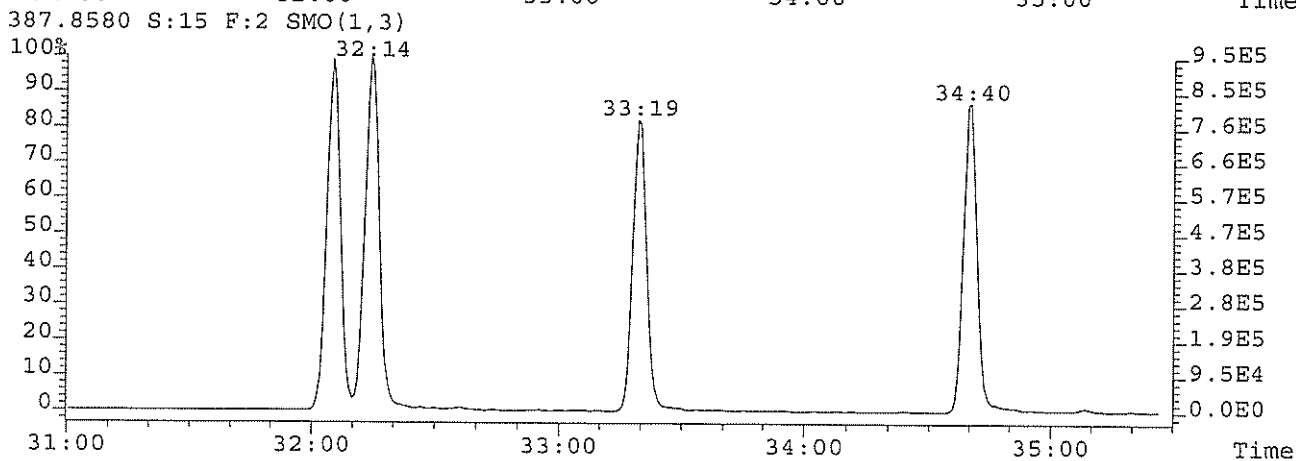
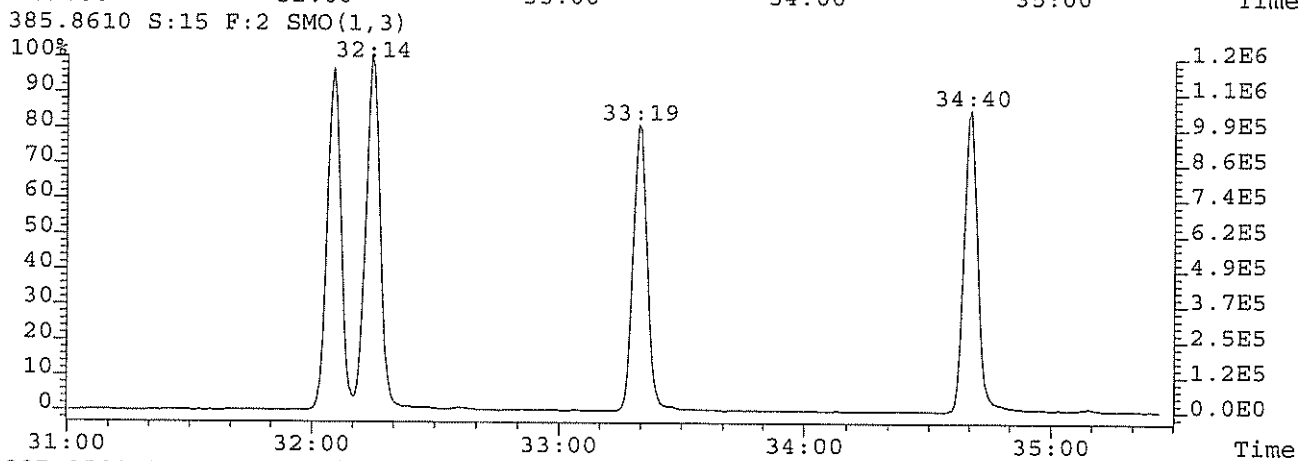
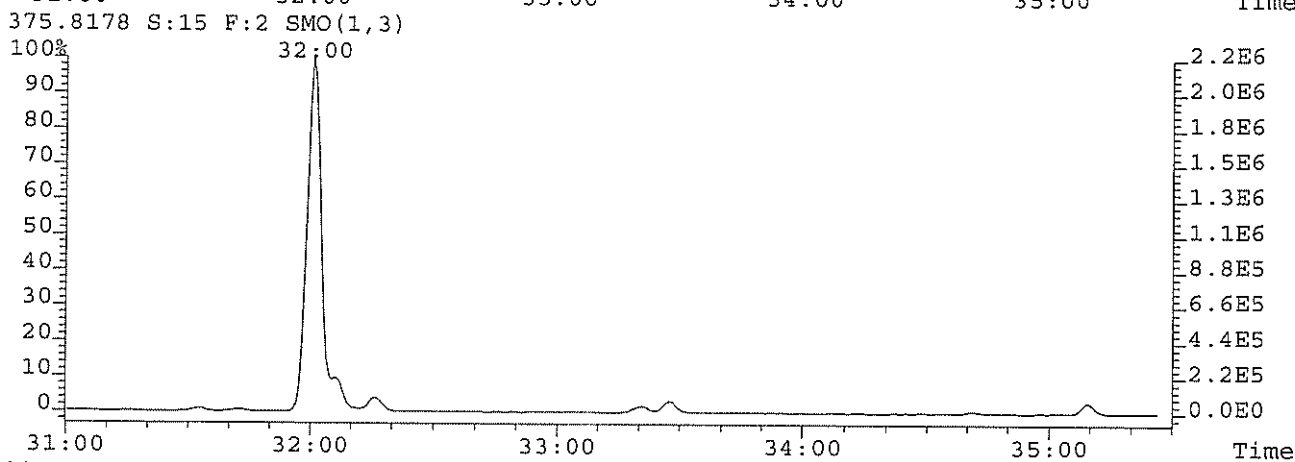
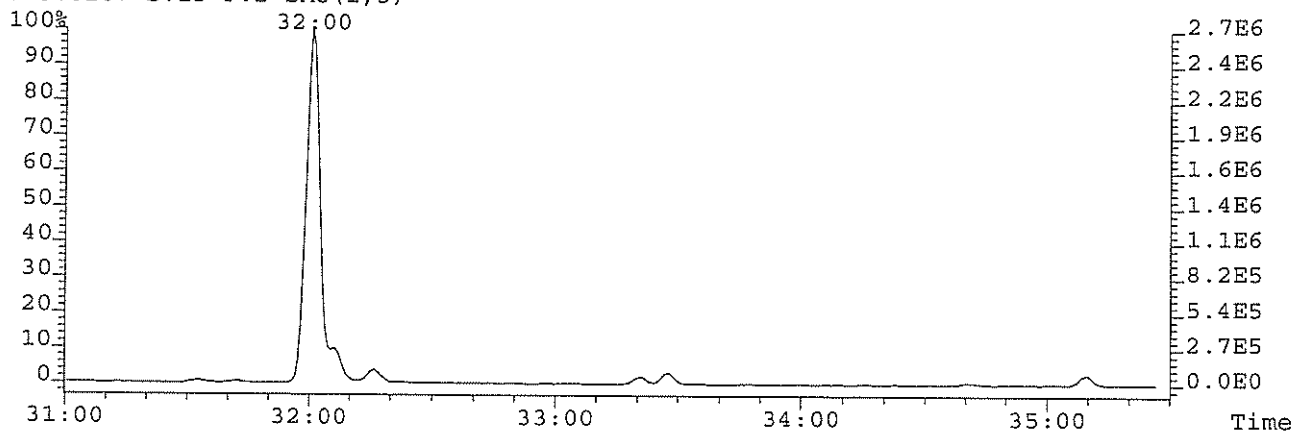
File:130711-2 #1-649 Acq:12-JUL-2013 06:25:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0953 3 Exp:RH-PD22  
339.8597 S:15 F:2 SMO(1,3)



PeCDFsクロマトグラム (7)  
(23478-PeCDF)

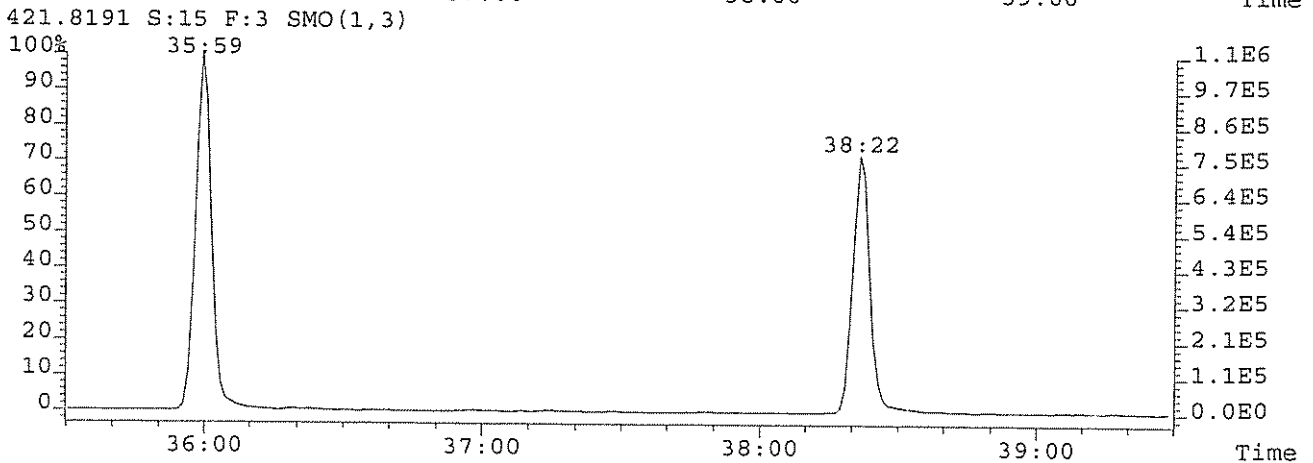
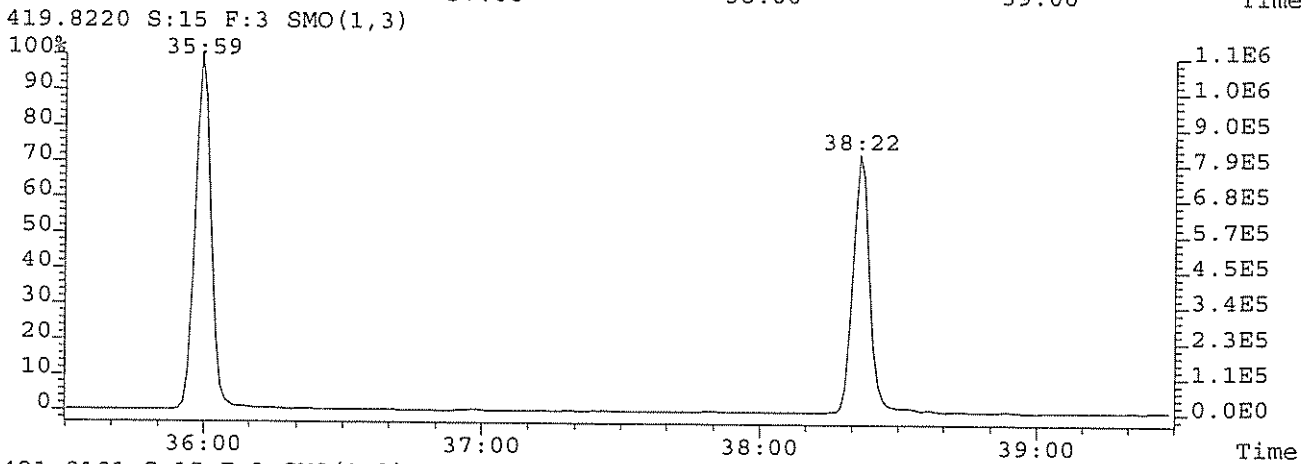
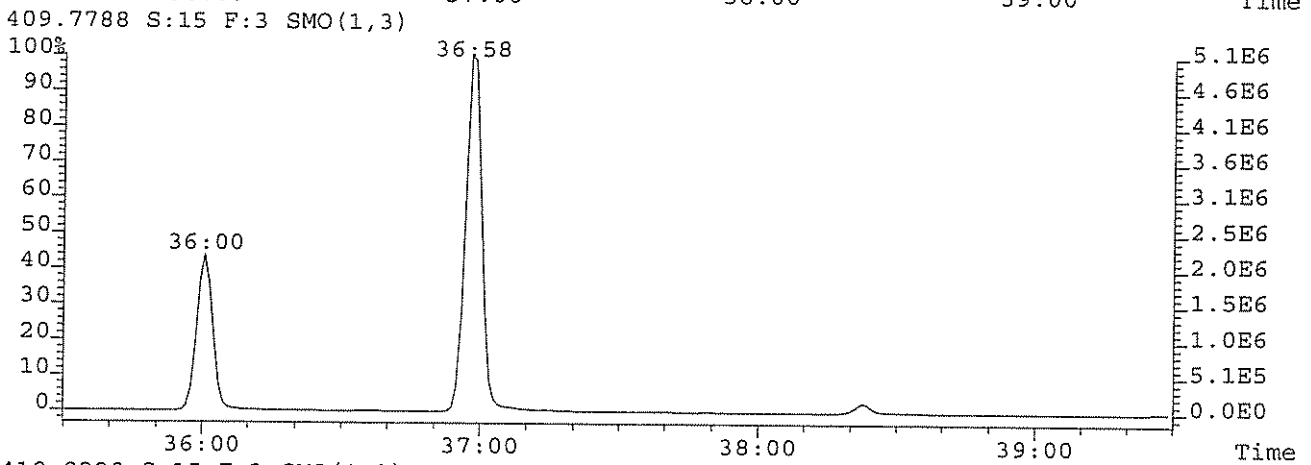
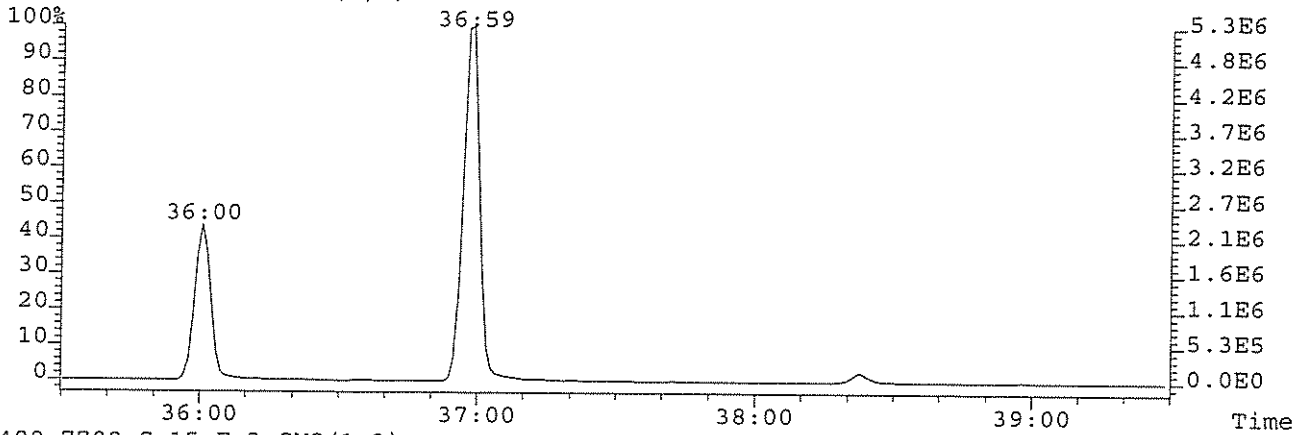


File:130711-2 #1-649 Acq:12-JUL-2013 06:25:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0953 3 Exp:RH-PD22



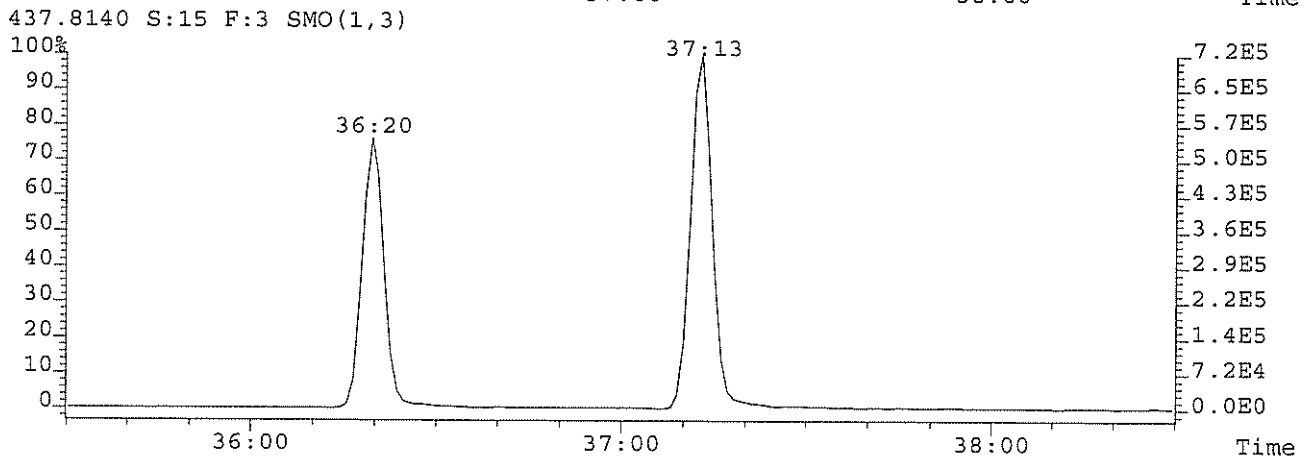
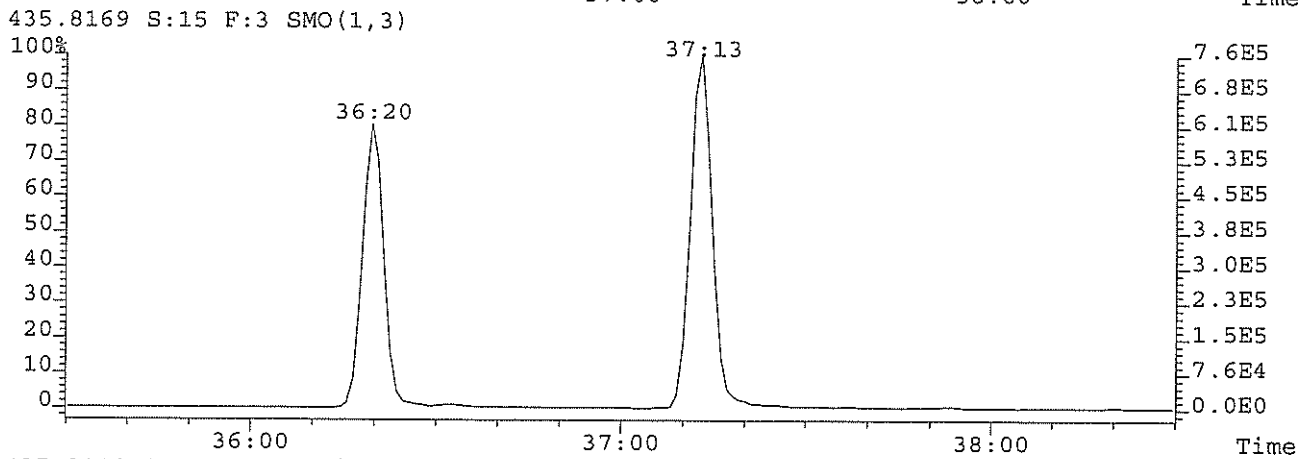
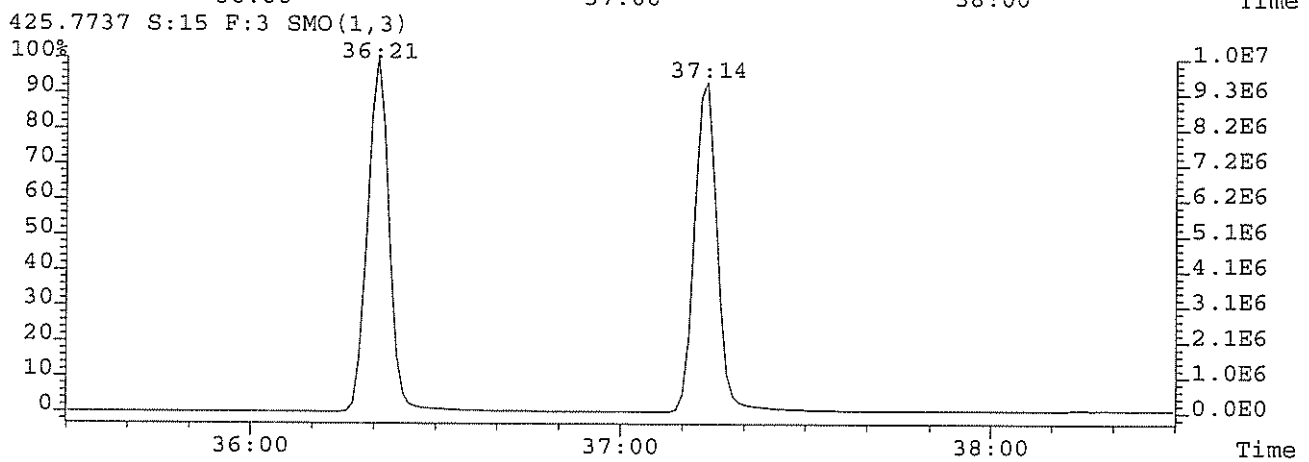
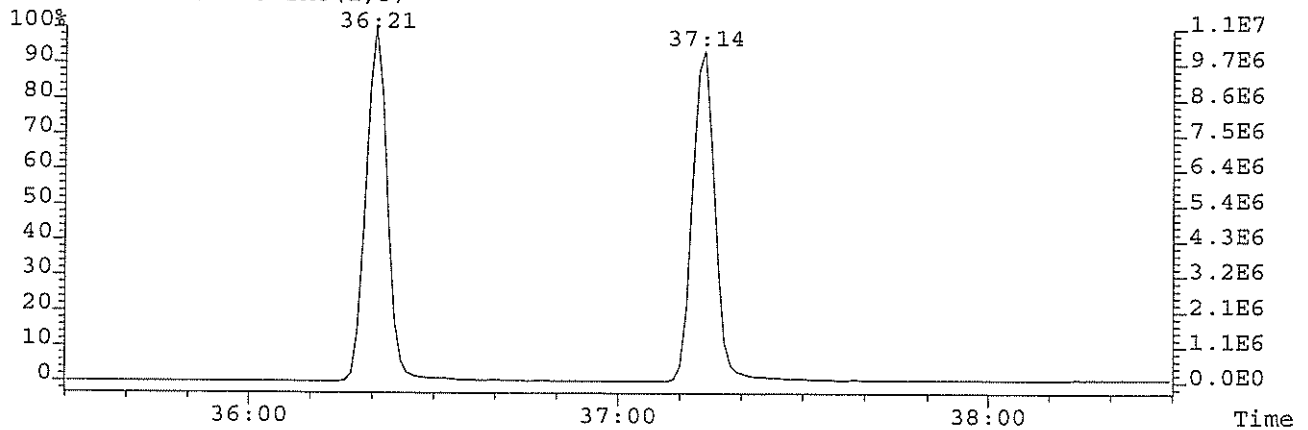
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130711-2 #1-562 Acq:12-JUL-2013 06:25:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0953 3 Exp:RH-PD22  
407.7818 S:15 F:3 SMO(1,3)



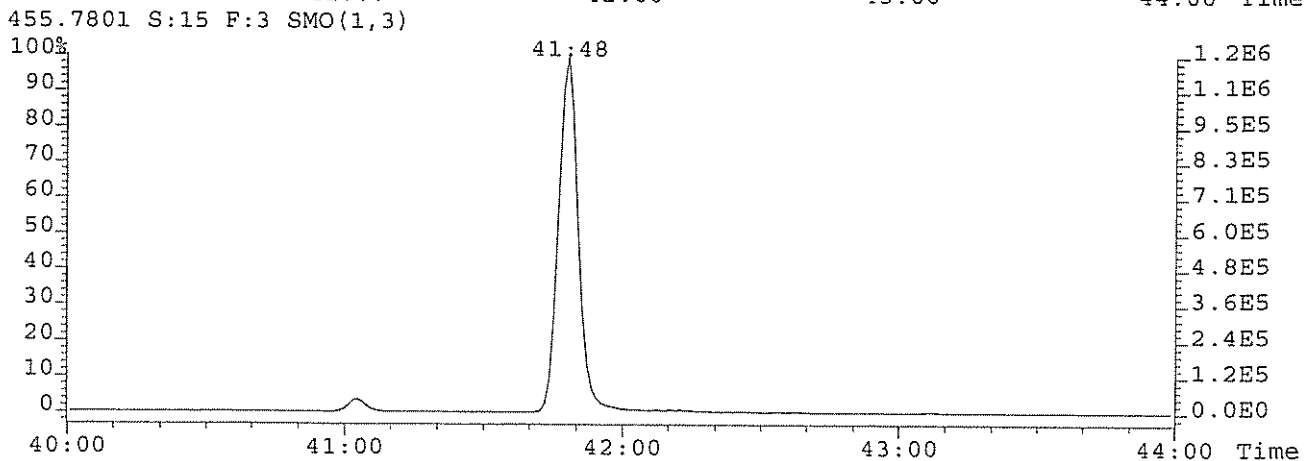
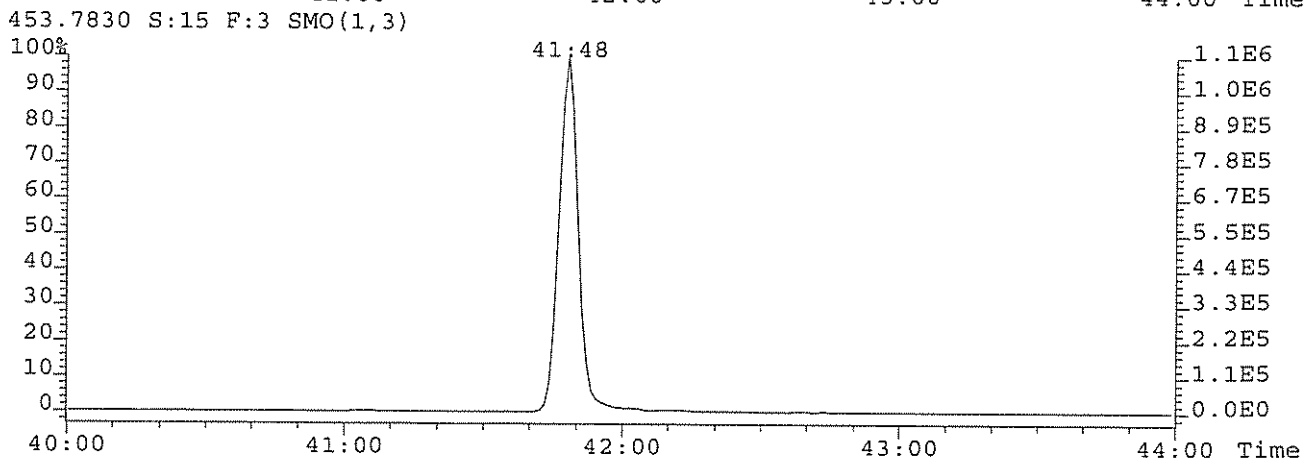
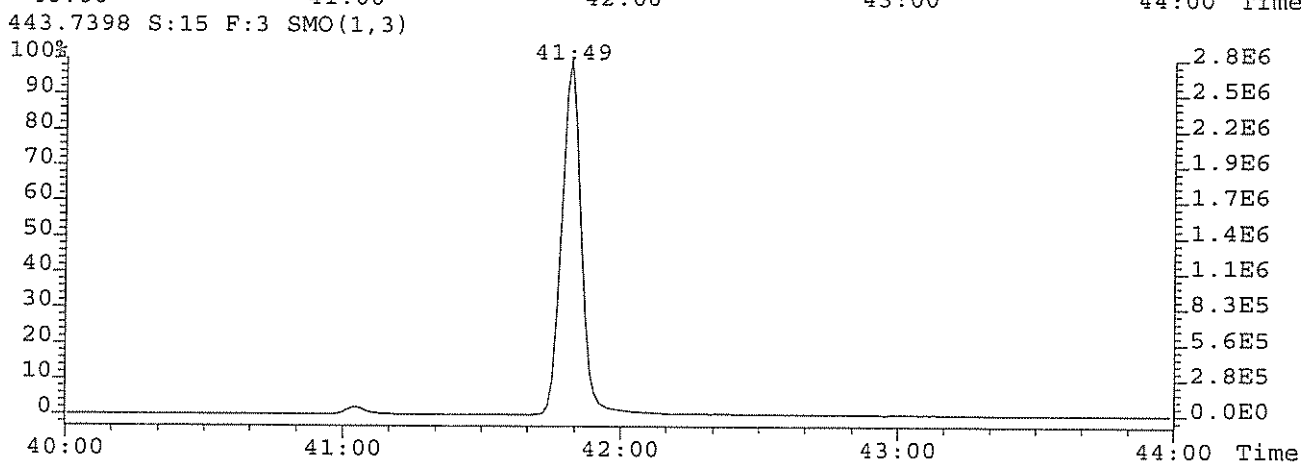
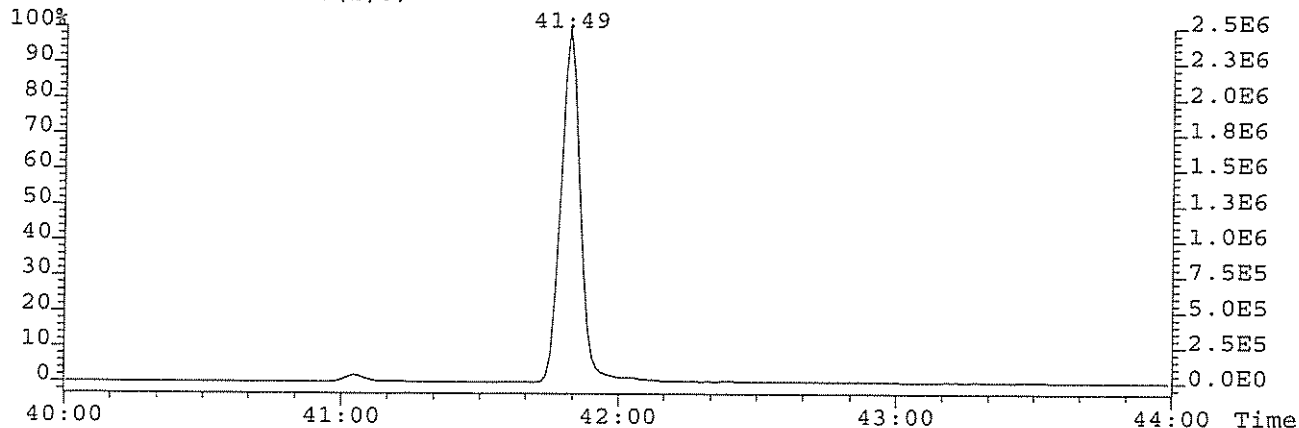
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130711-2 #1-562 Acq:12-JUL-2013 06:25:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0953 3 Exp:RH-PD22



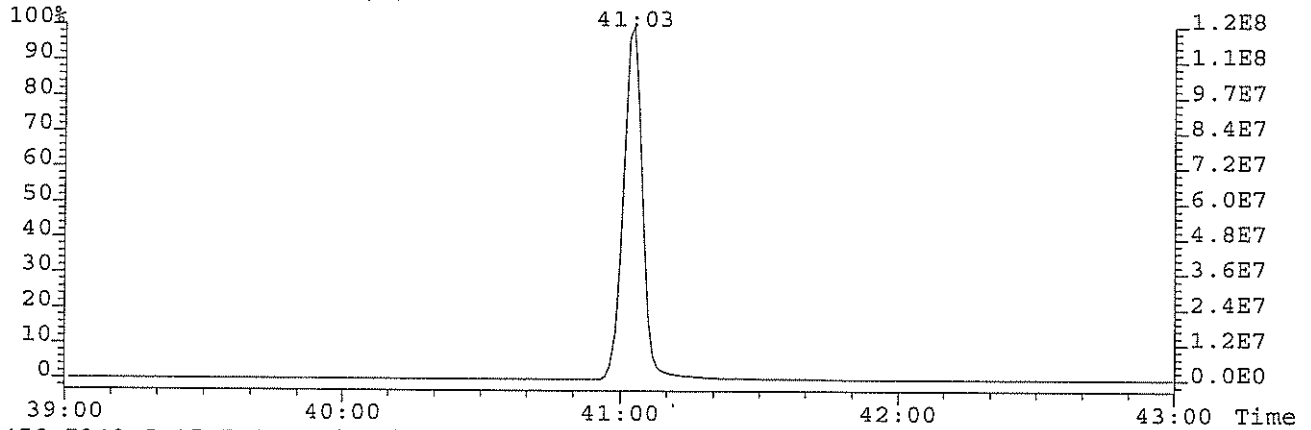
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130711-2 #1-562 Acq:12-JUL-2013 06:25:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0953 3 Exp:RH-PD22  
441.7428 S:15 F:3 SMO(1,3)

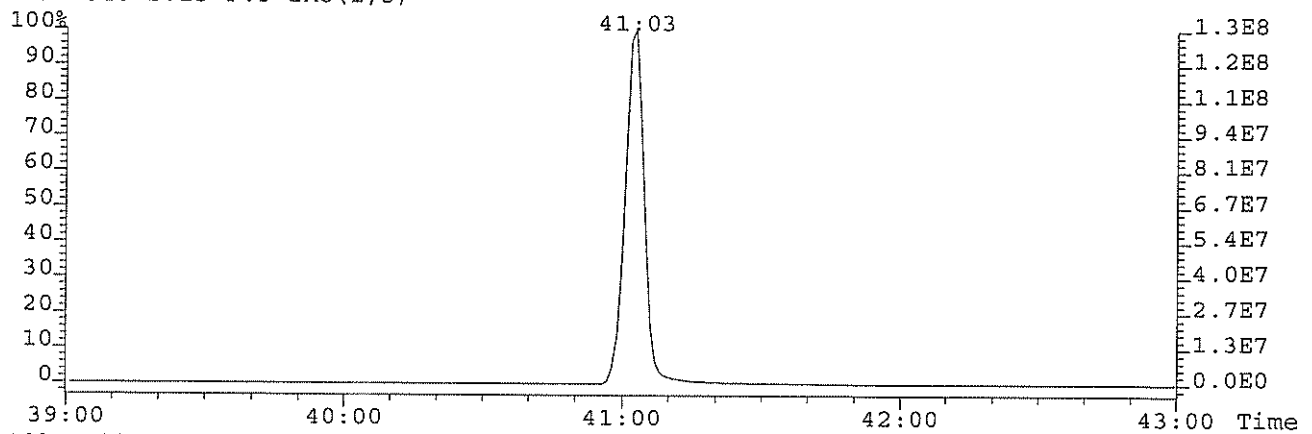


PCDFsクロマトグラム (11)  
(OCDF)

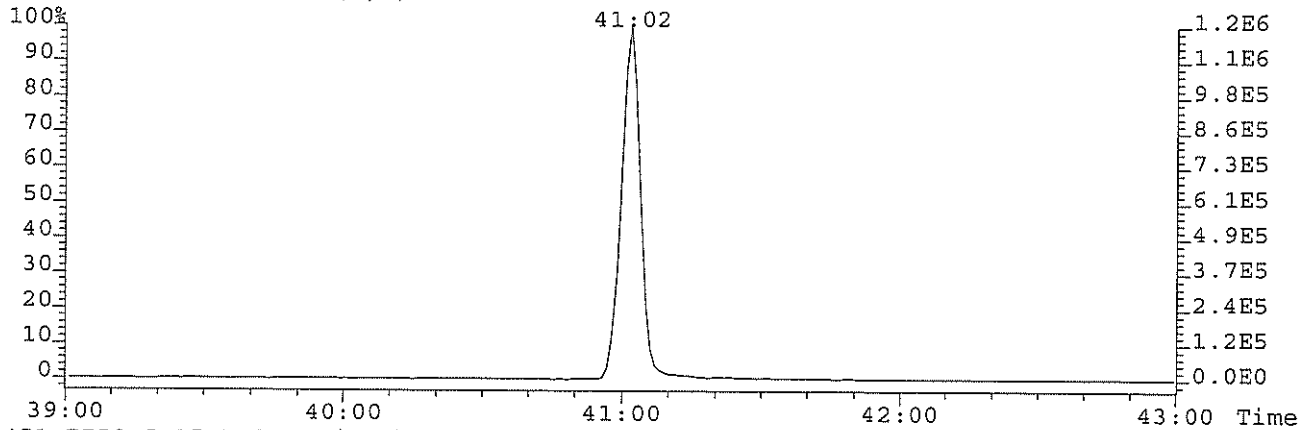
File:130711-2 #1-562 Acq:12-JUL-2013 06:25:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0953 3 Exp:RH-PD22  
457.7377 S:15 F:3 SMO(1,3)



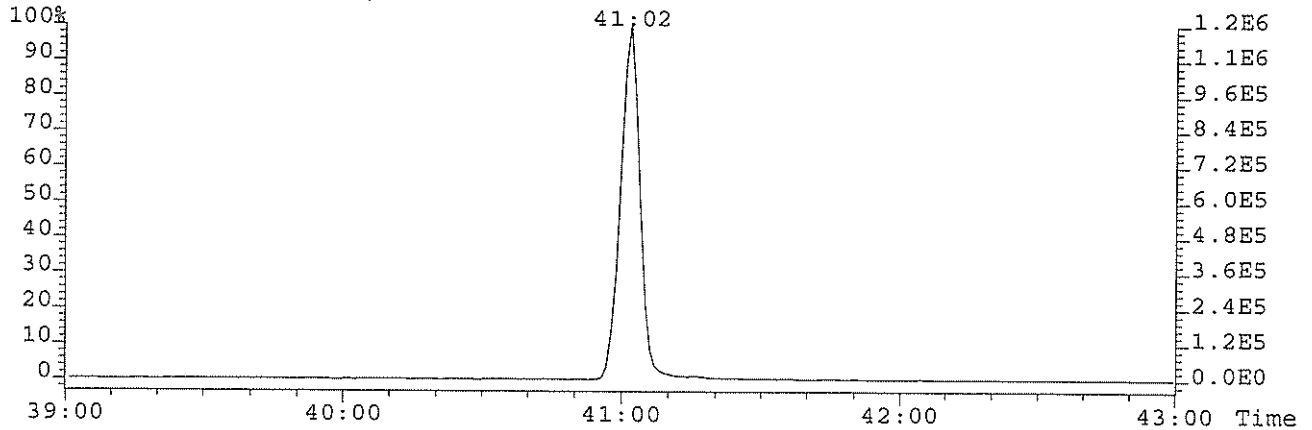
459.7348 S:15 F:3 SMO(1,3)



469.7780 S:15 F:3 SMO(1,3)

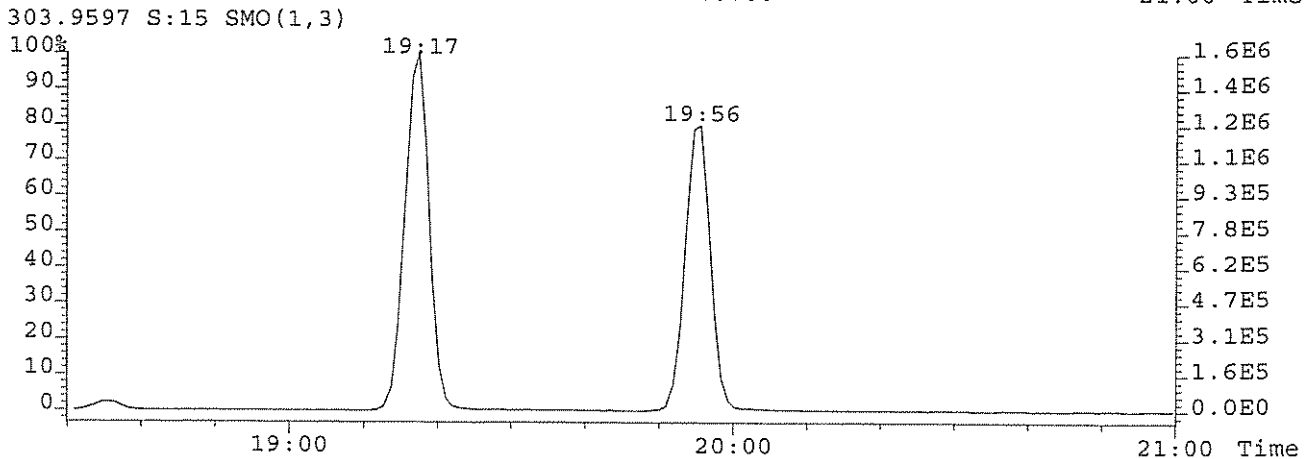
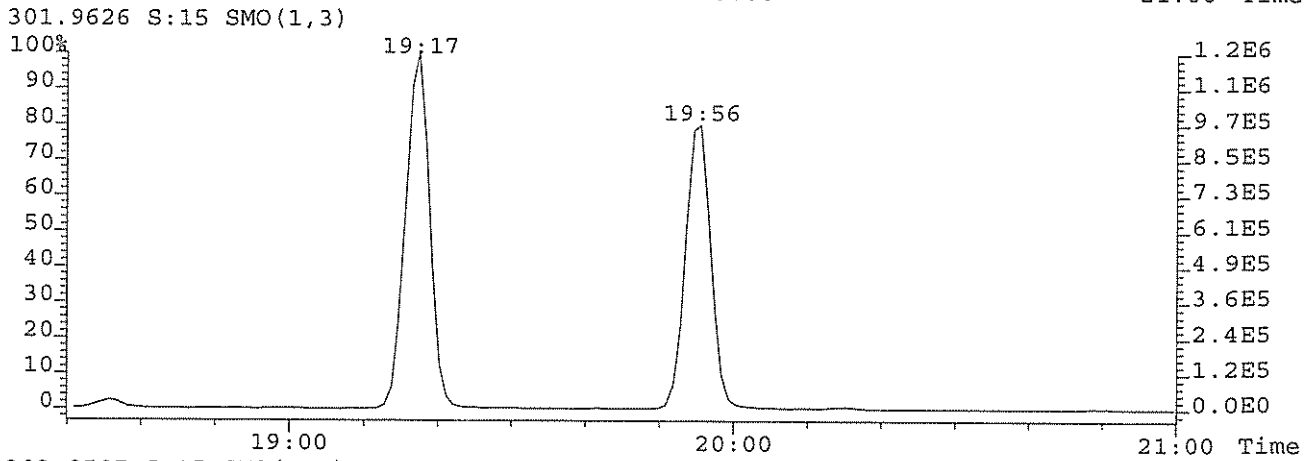
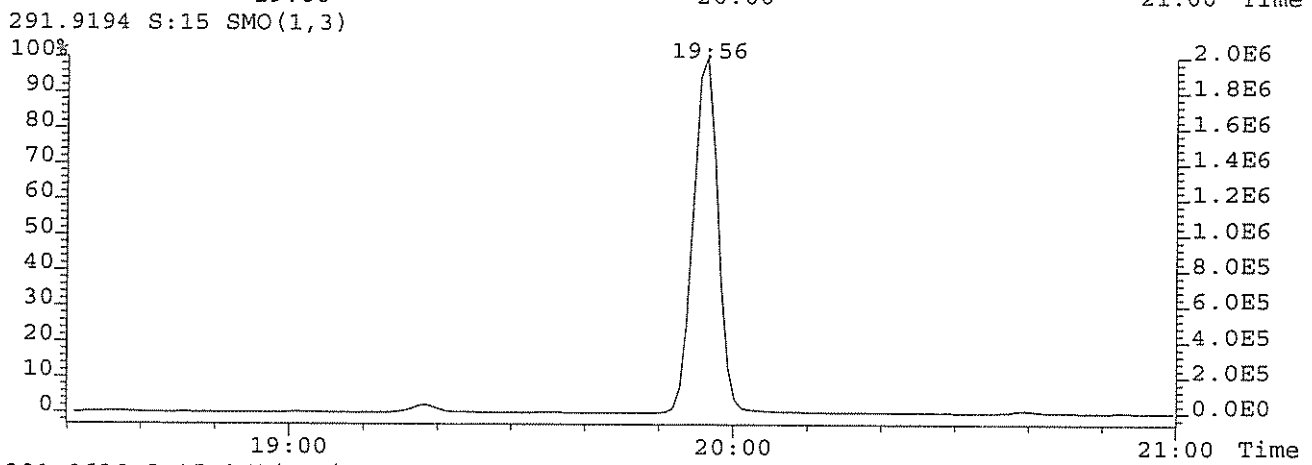
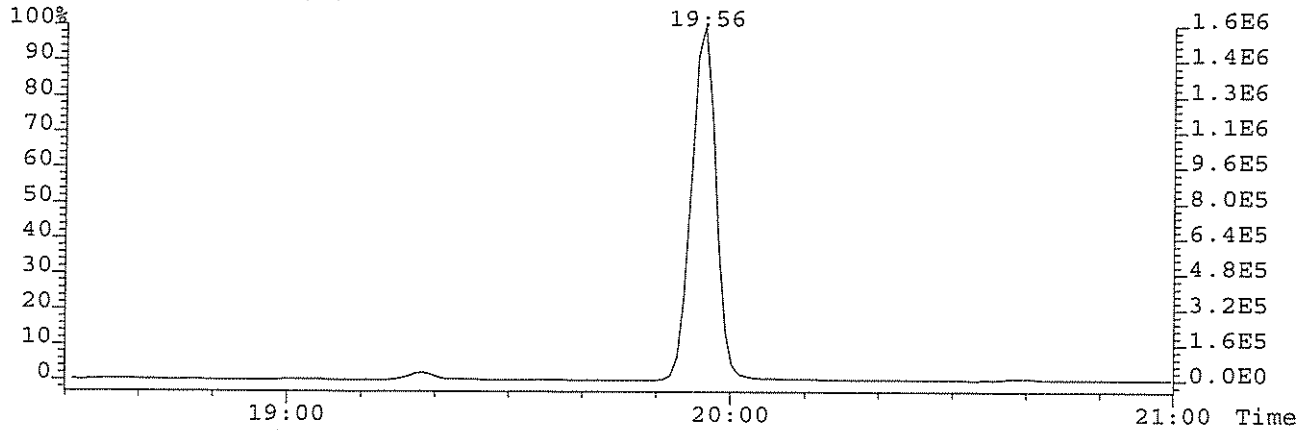


471.7750 S:15 F:3 SMO(1,3)



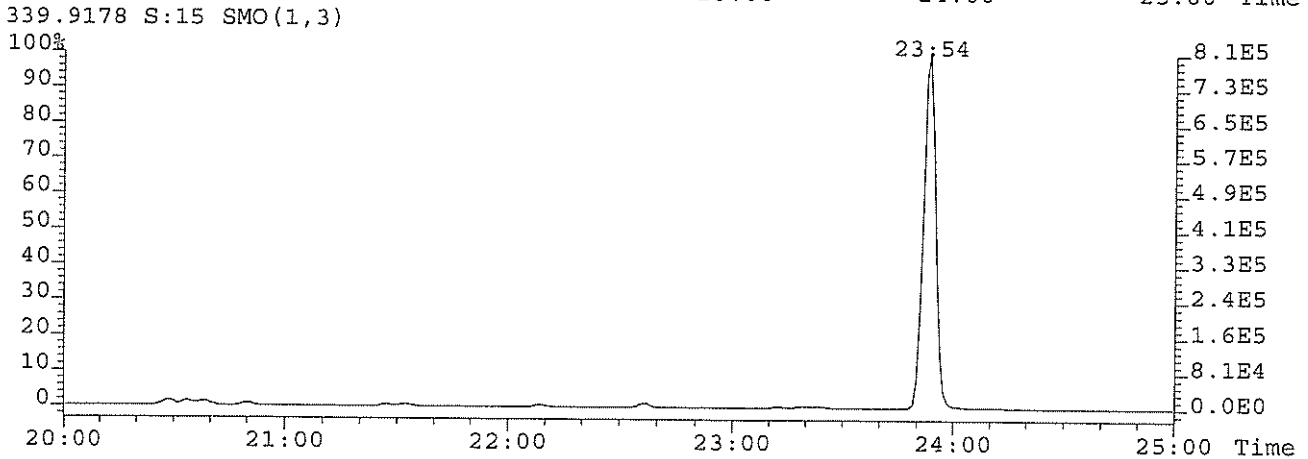
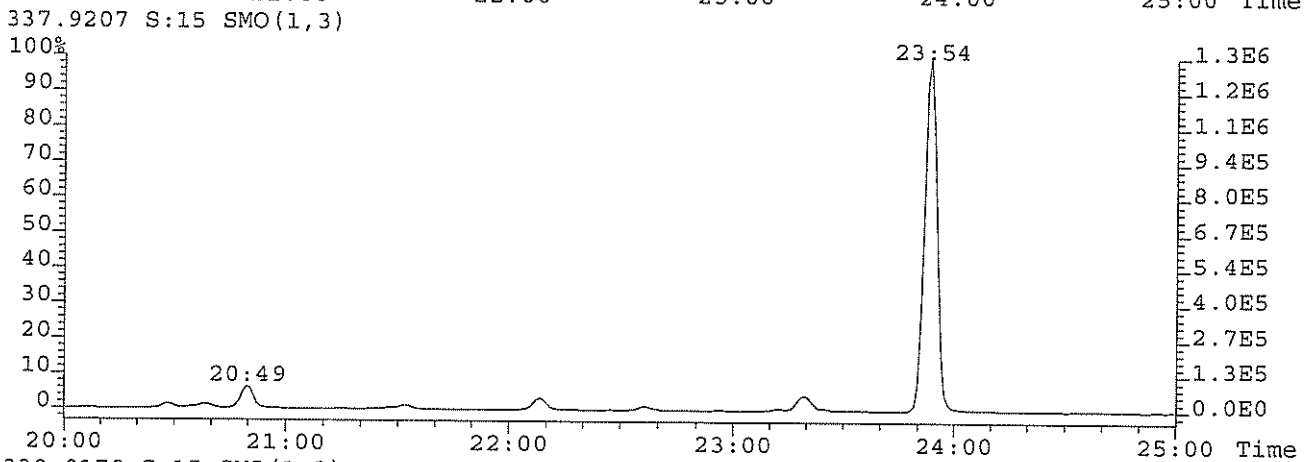
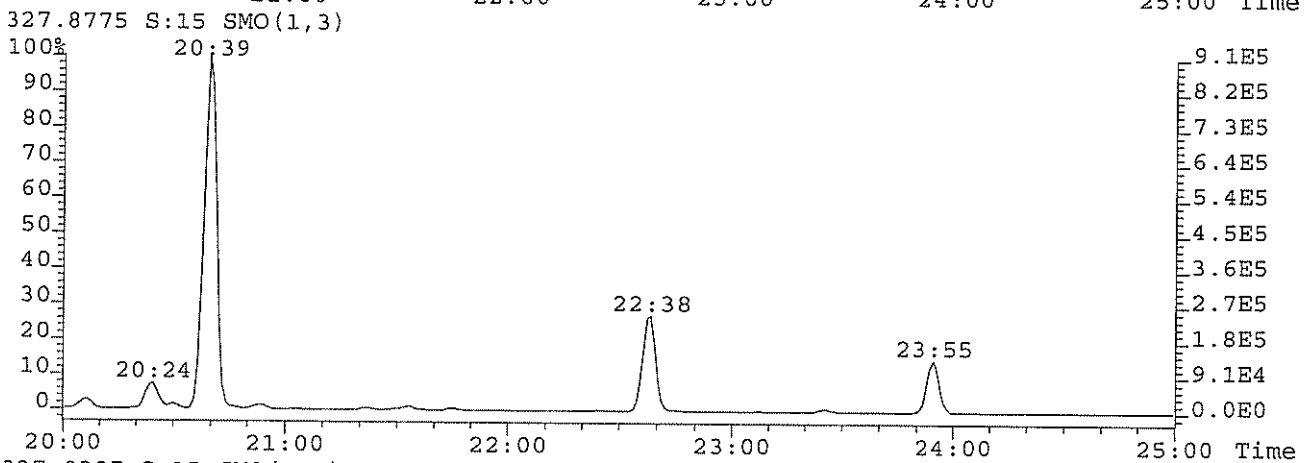
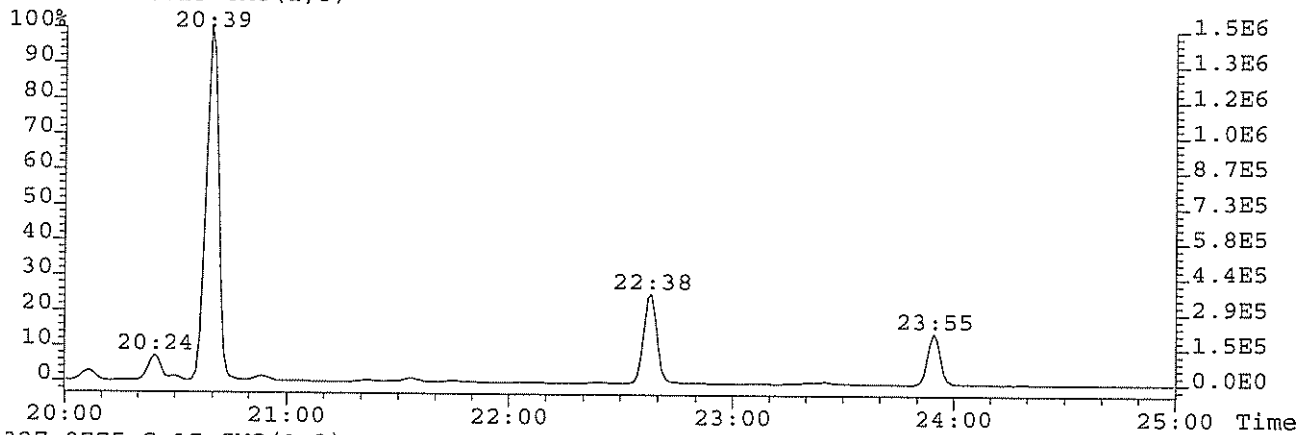
PCDDsクロマトグラム (12)  
(OCDD)

File:130711-2 #1-1430 Acq:12-JUL-2013 06:25:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0953 3 Exp:RH-PD22  
289.9224 S:15 SMO(1,3)



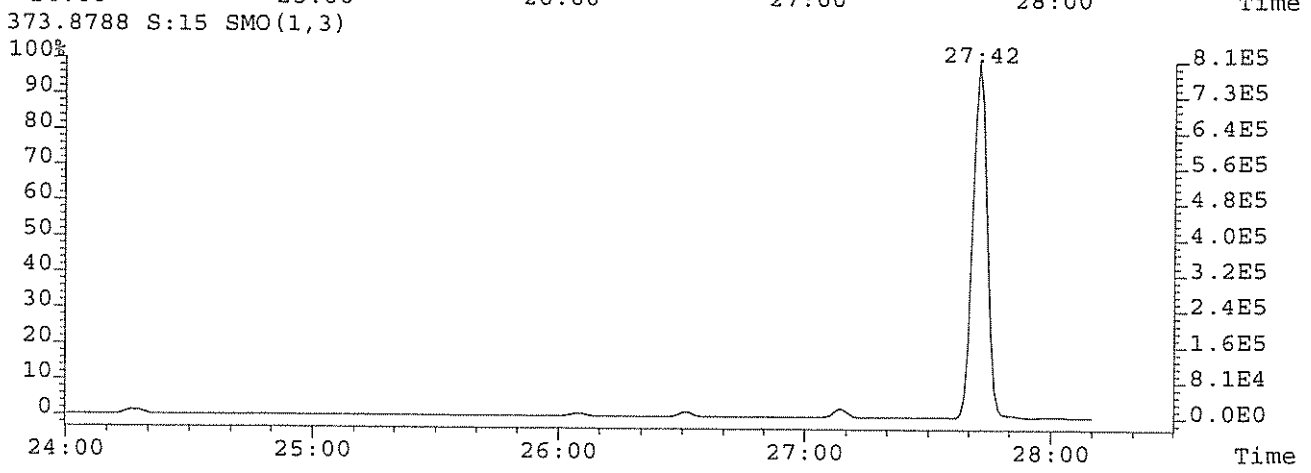
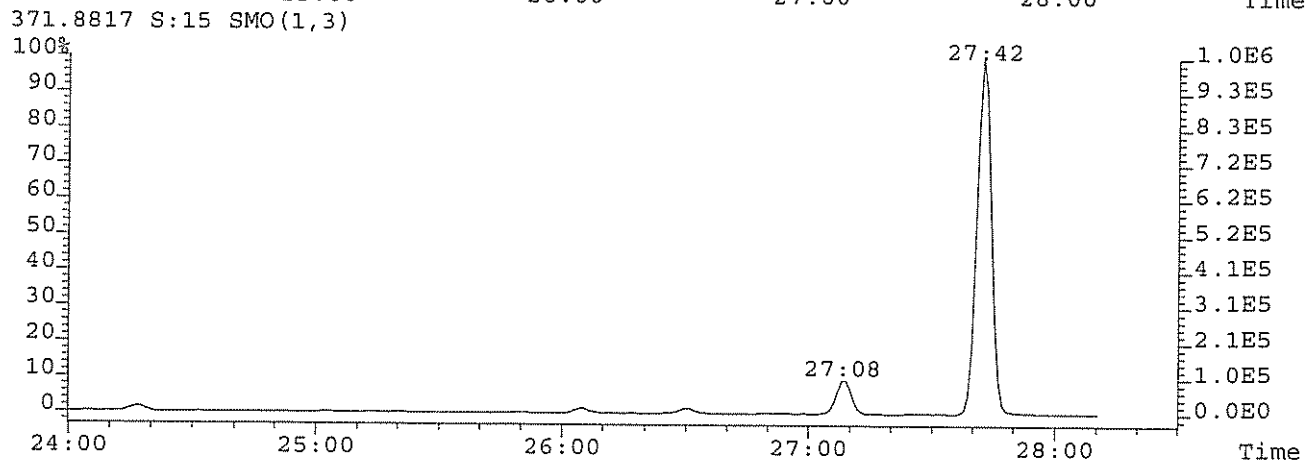
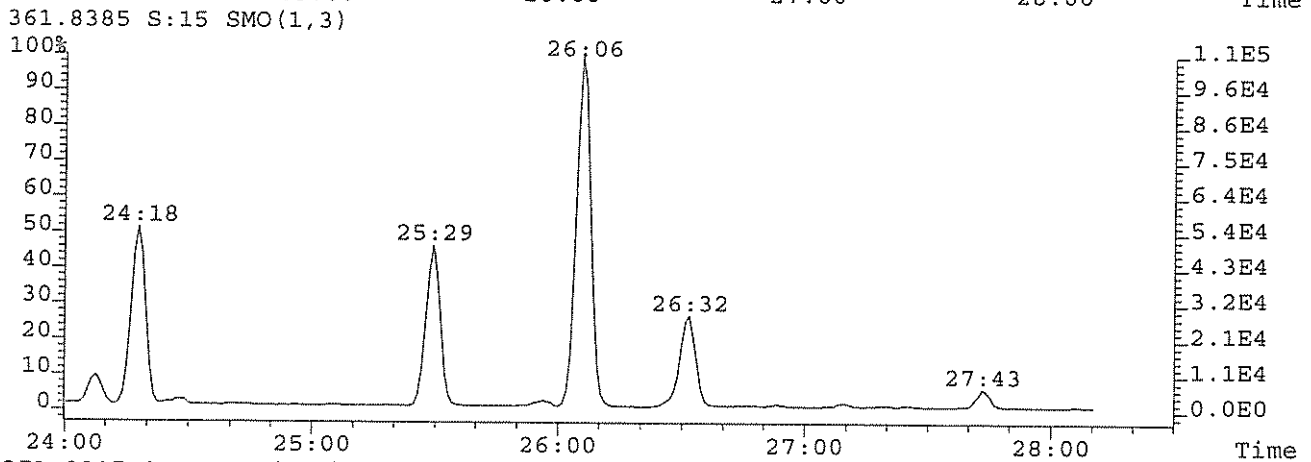
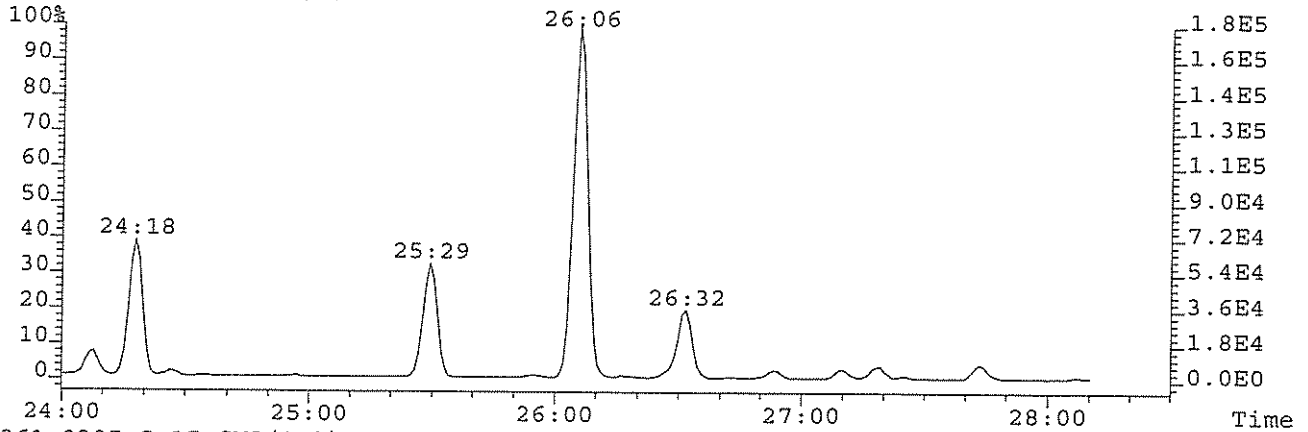
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 06:25:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0953 3 Exp:RH-PD22



DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 06:25:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0953 3 Exp:RH-PD22  
359.8415 S:15 SMO(1,3)

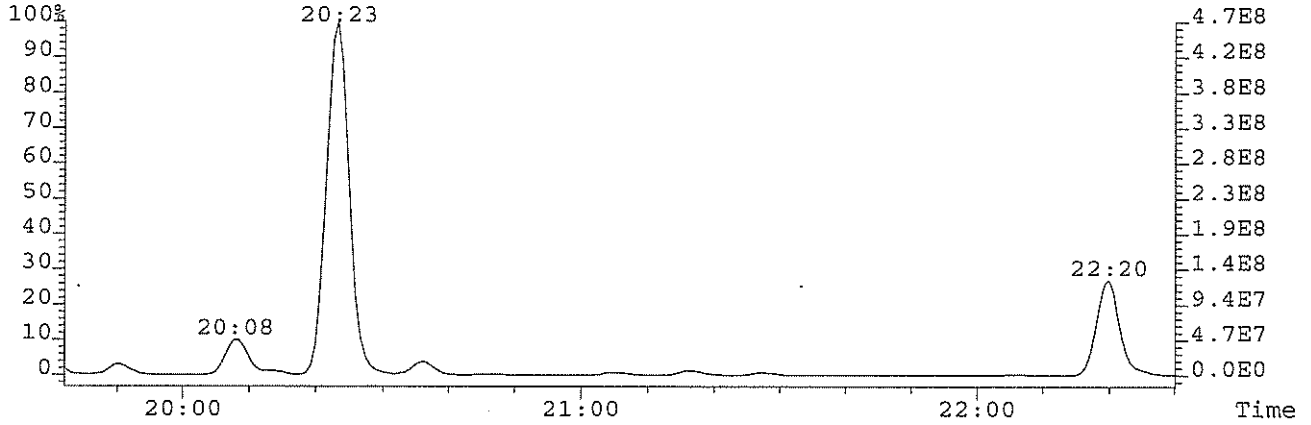


DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

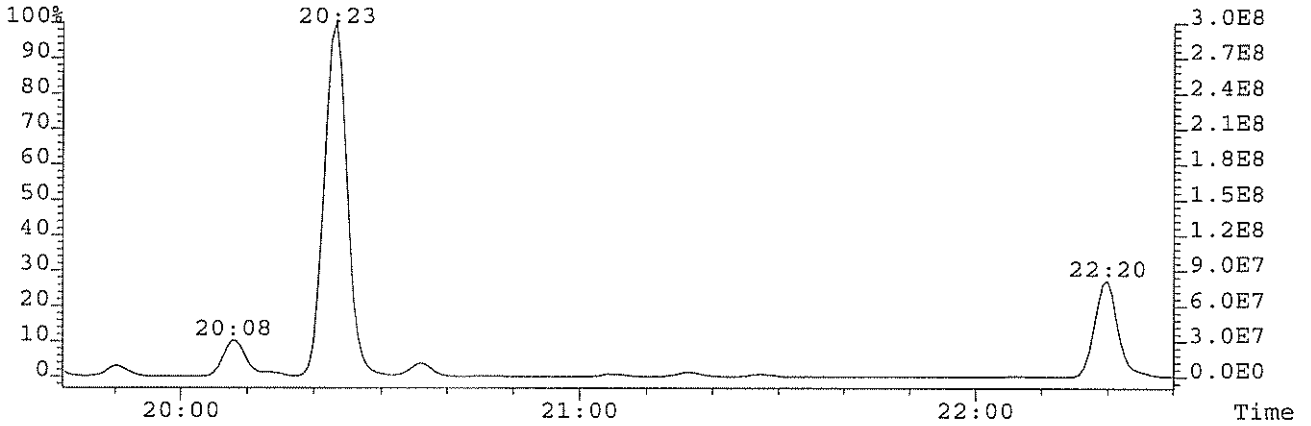


File:130713 #1-2899 Acq:14-JUL-2013 04:10:51 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#24 File Text:RH-12ms(mP) Text:XE13 0953 2 Exp:RH-MP11

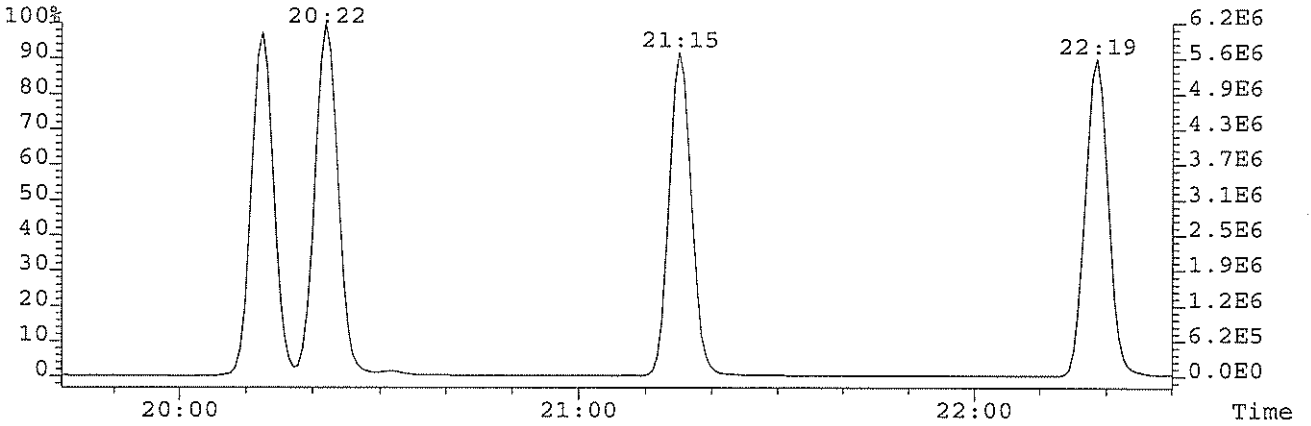
325.8804 S:24 SMO(1,3)



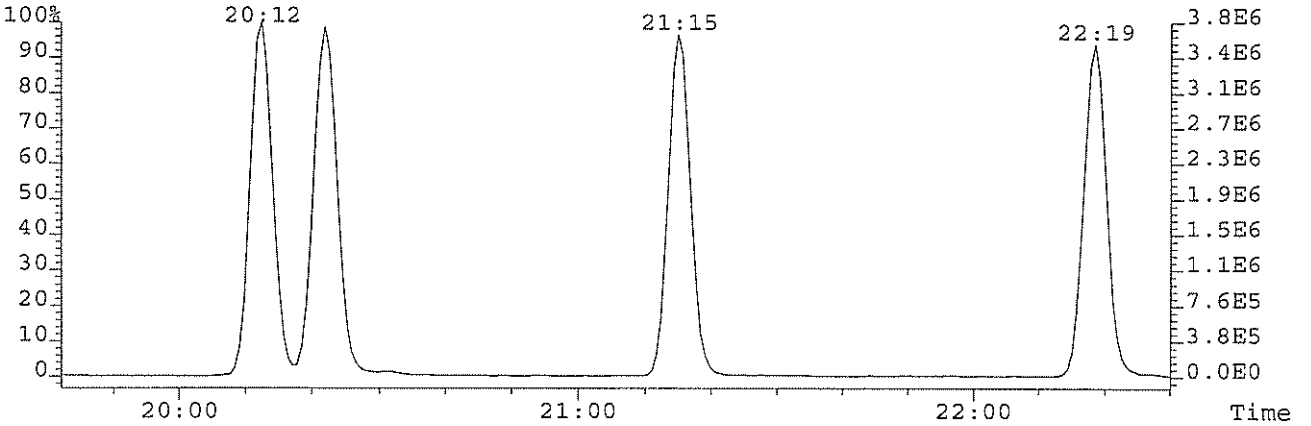
327.8775 S:24 SMO(1,3)



337.9207 S:24 SMO(1,3)

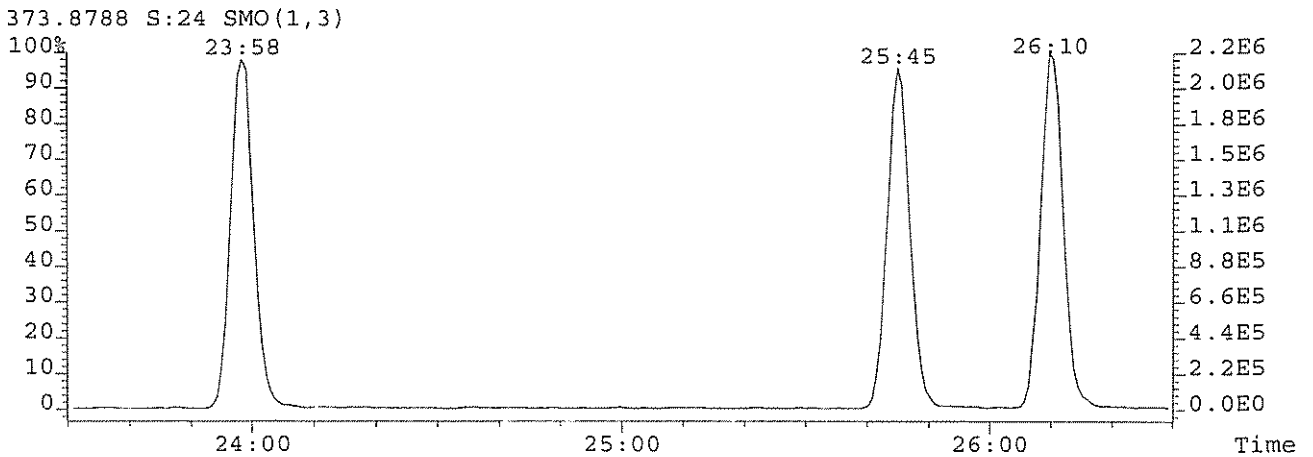
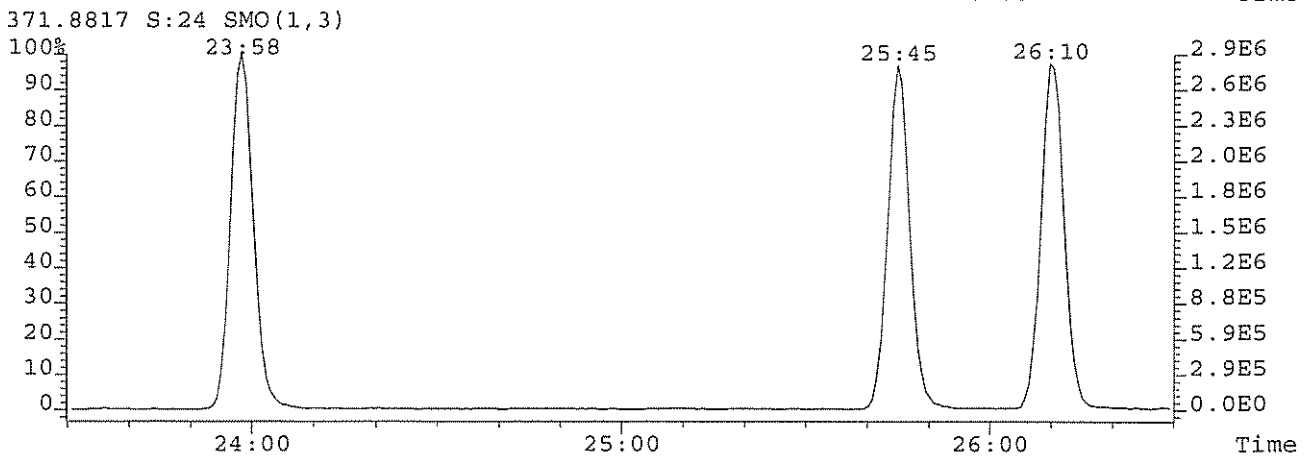
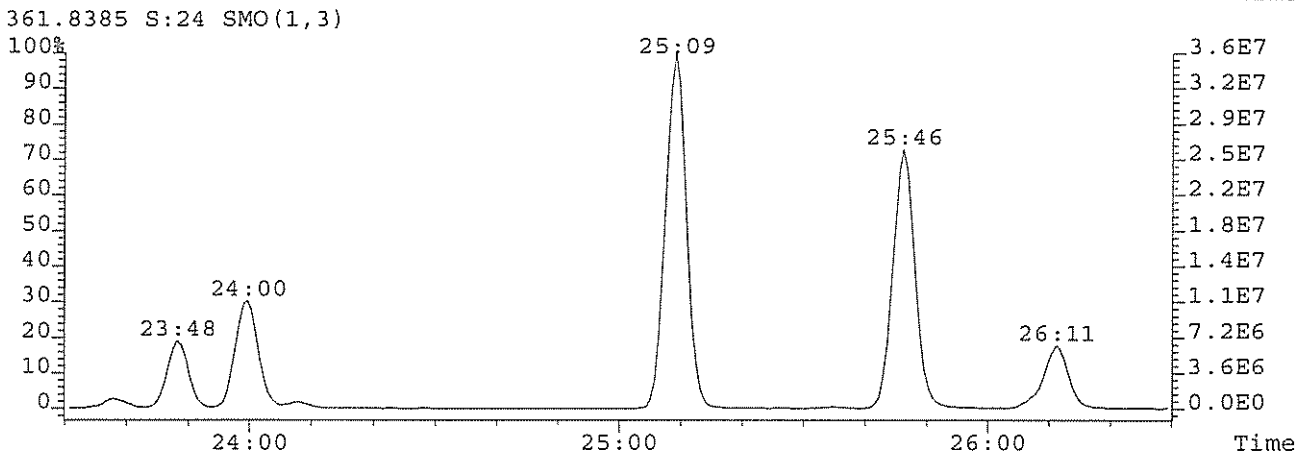
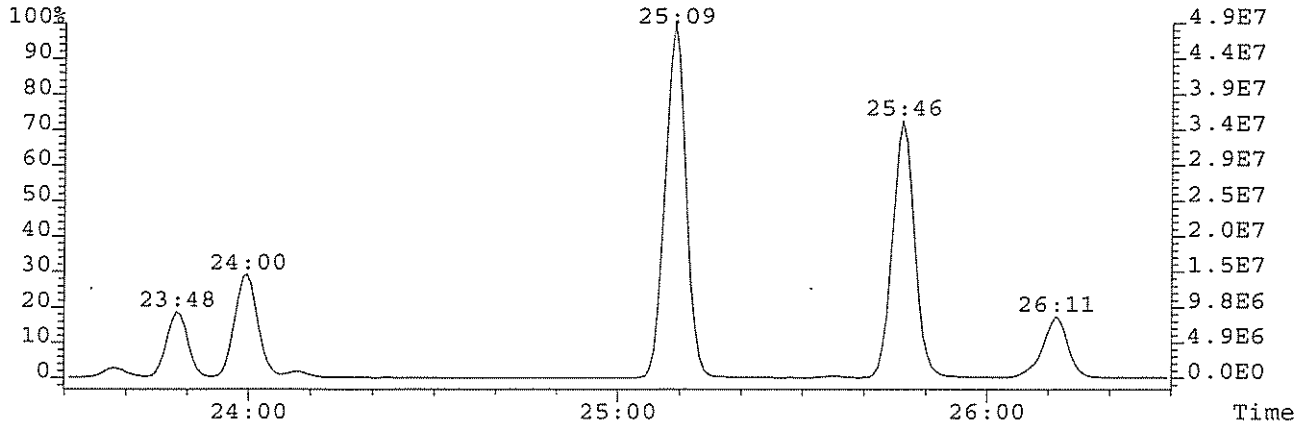


339.9178 S:24 SMO(1,3)



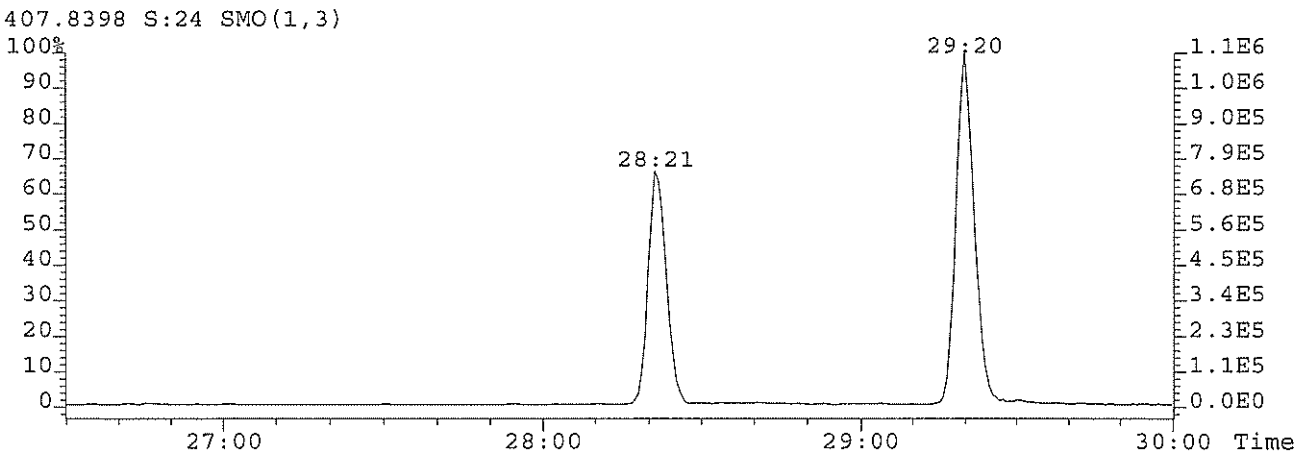
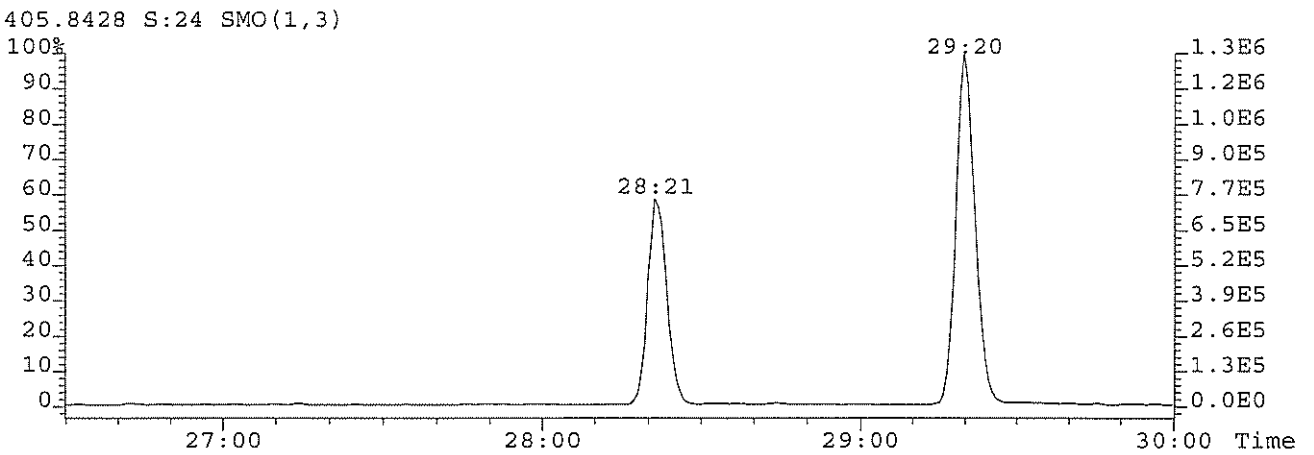
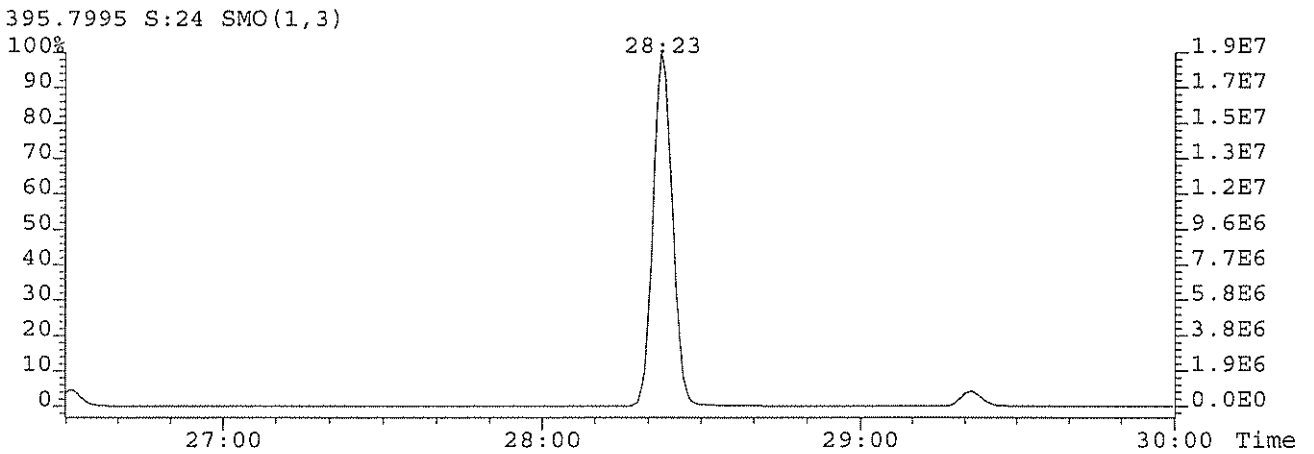
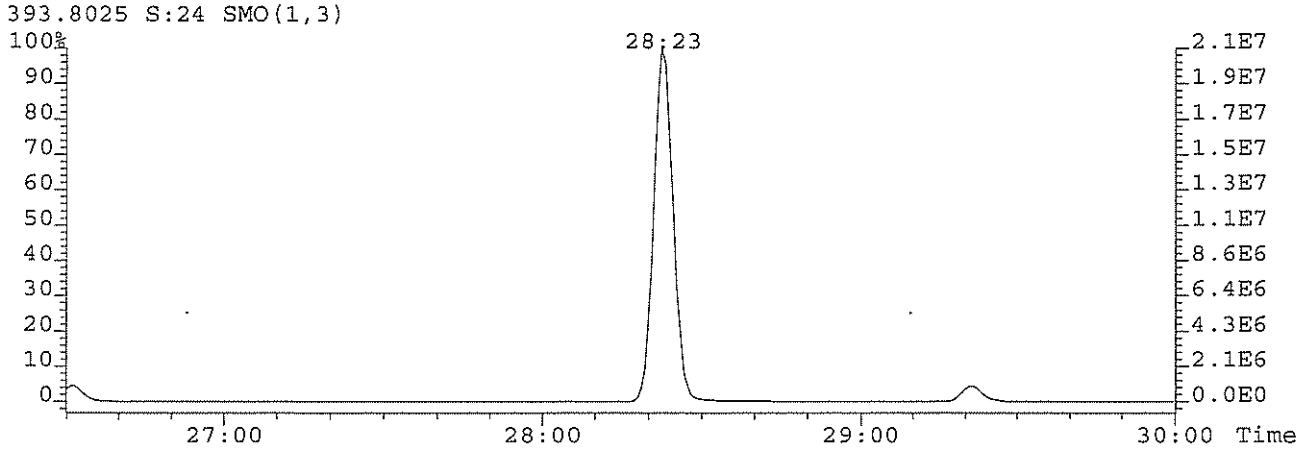
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130713 #1-2899 Acq:14-JUL-2013 04:10:51 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#24 File Text:RH-12ms(mP) Text:XE13 0953 2 Exp:RH-MP11  
359.8415 S:24 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130713 #1-2899 Acq:14-JUL-2013 04:10:51 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#24 File Text:RH-12ms(mP) Text:XE13 0953 2 Exp:RH-MP11

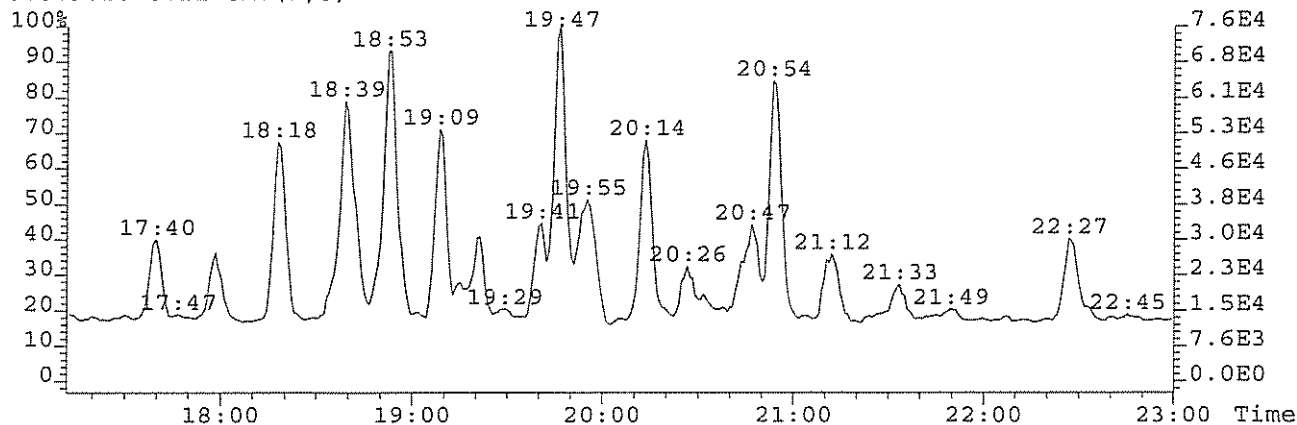


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

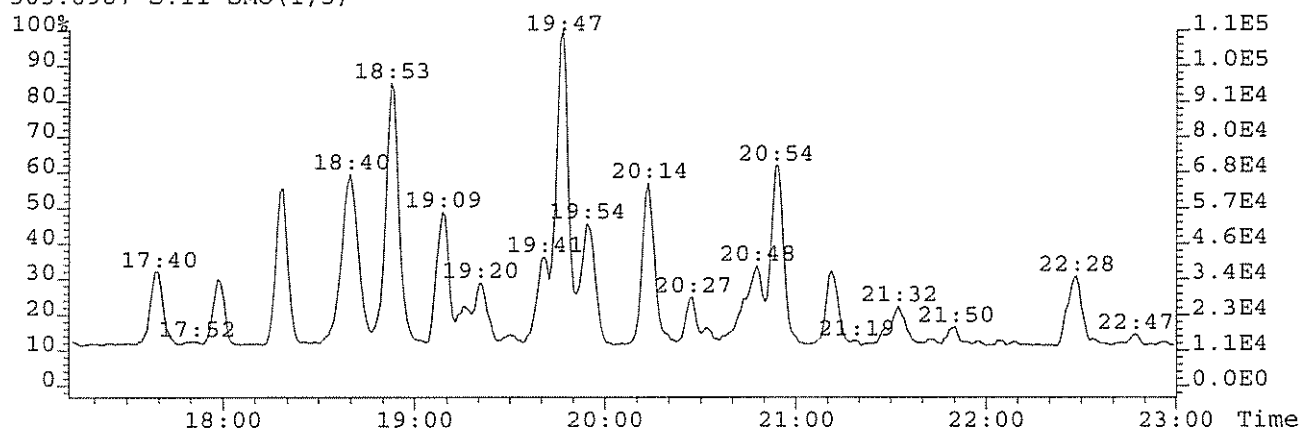
試料管理番号	XE 130954
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.8

File:130712-2 #1-1578 Acq:13-JUL-2013 00:40:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:BPX-DXN(4-6DXN) Text:XE13 0954 Exp:BPX04

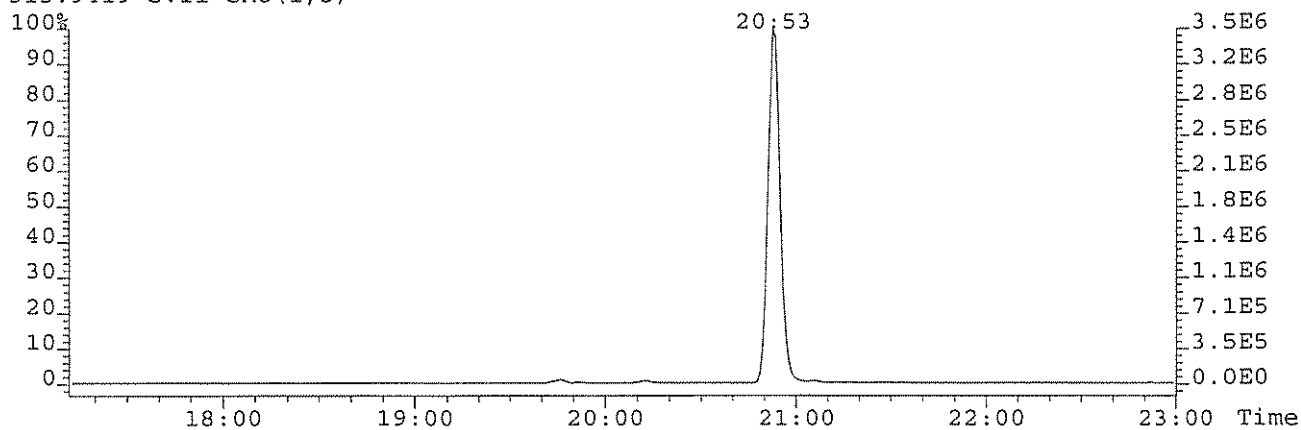
303.9016 S:11 SMO(1,3)



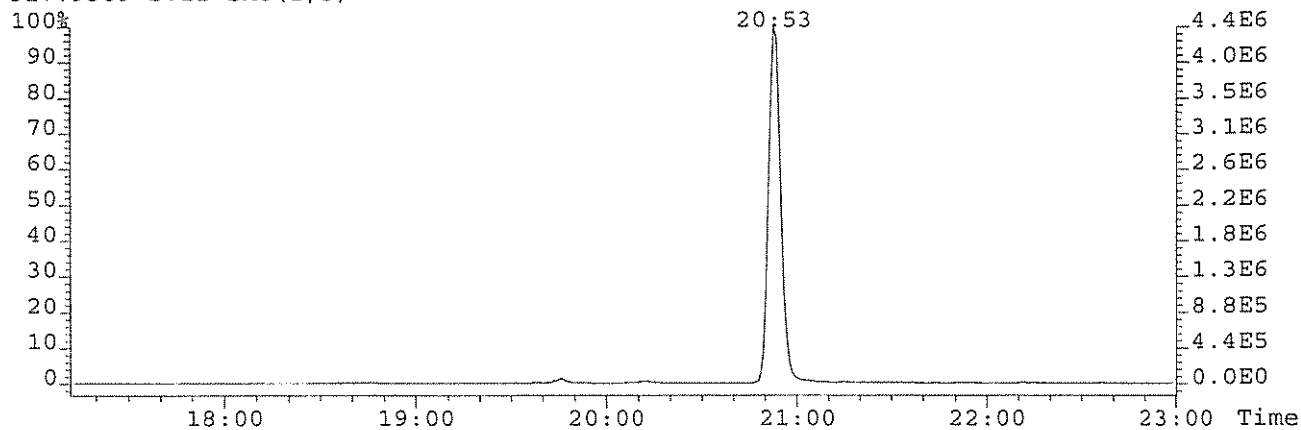
305.8987 S:11 SMO(1,3)



315.9419 S:11 SMO(1,3)



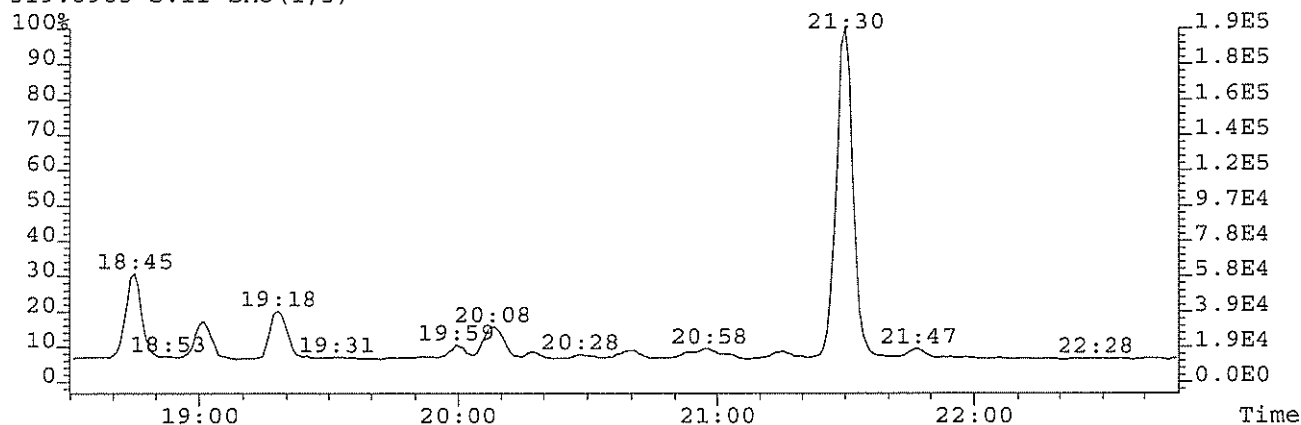
317.9389 S:11 SMO(1,3)



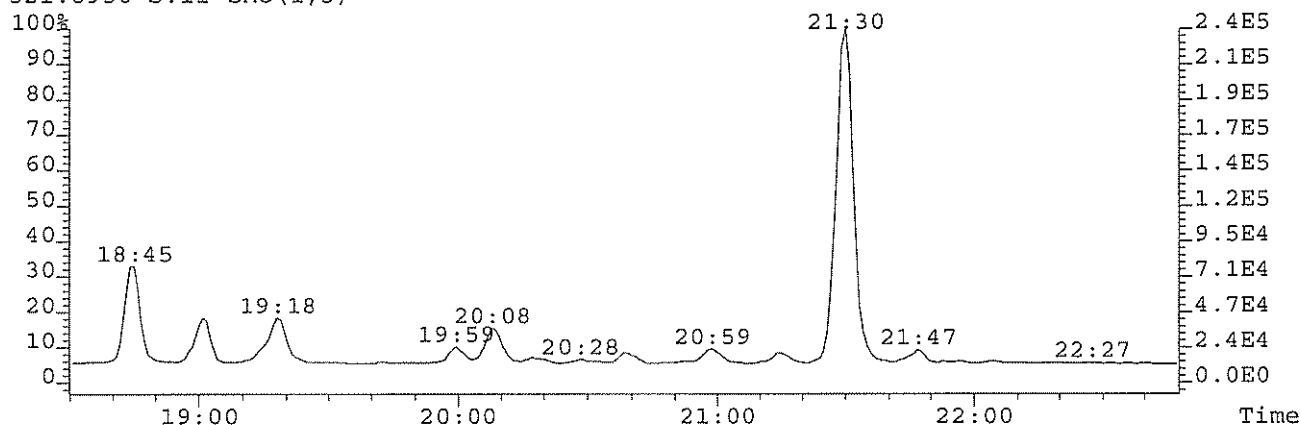
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 00:40:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:BPX-DXN(4-6DXN) Text:XE13 0954 Exp:BPX04

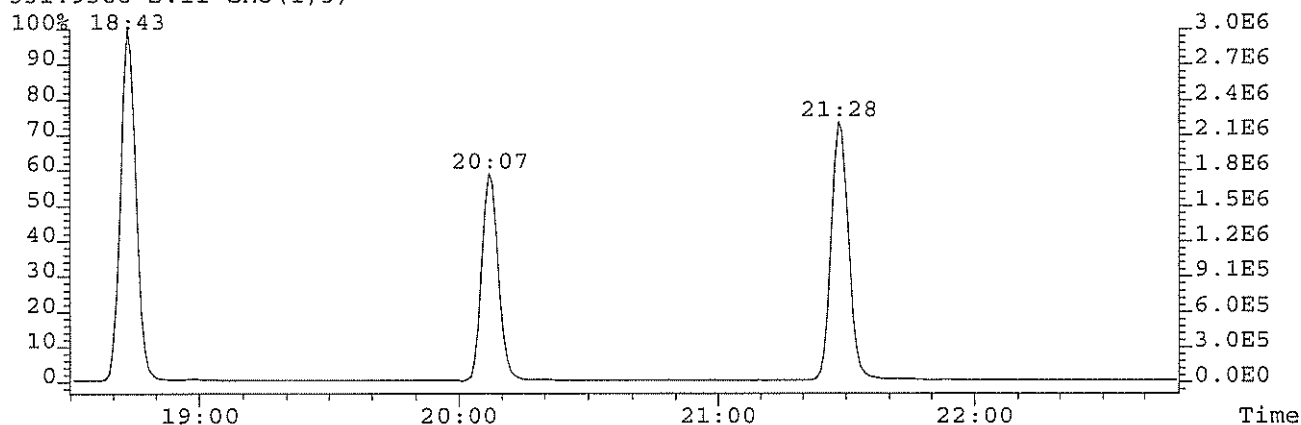
319.8965 S:11 SMO(1,3)



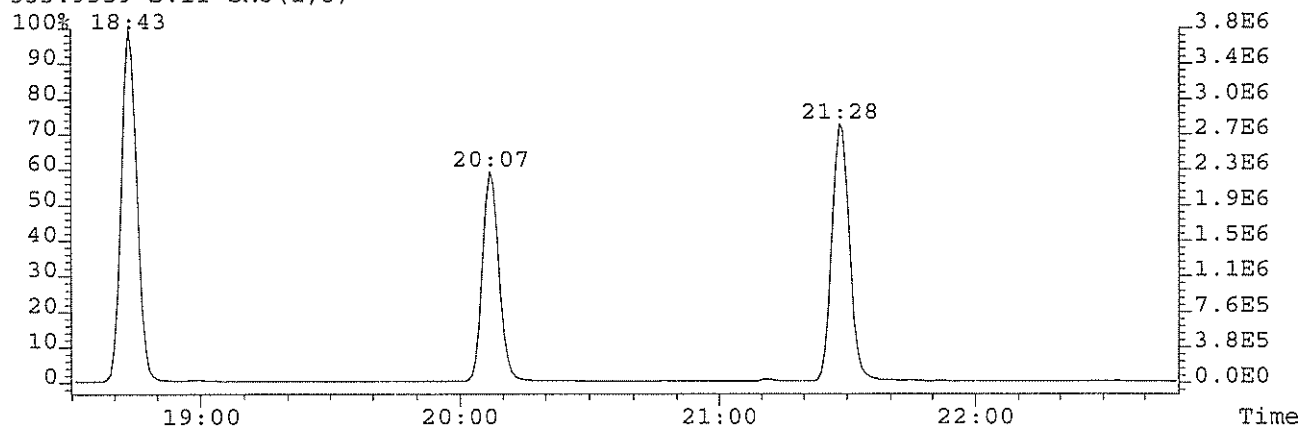
321.8936 S:11 SMO(1,3)



331.9368 S:11 SMO(1,3)



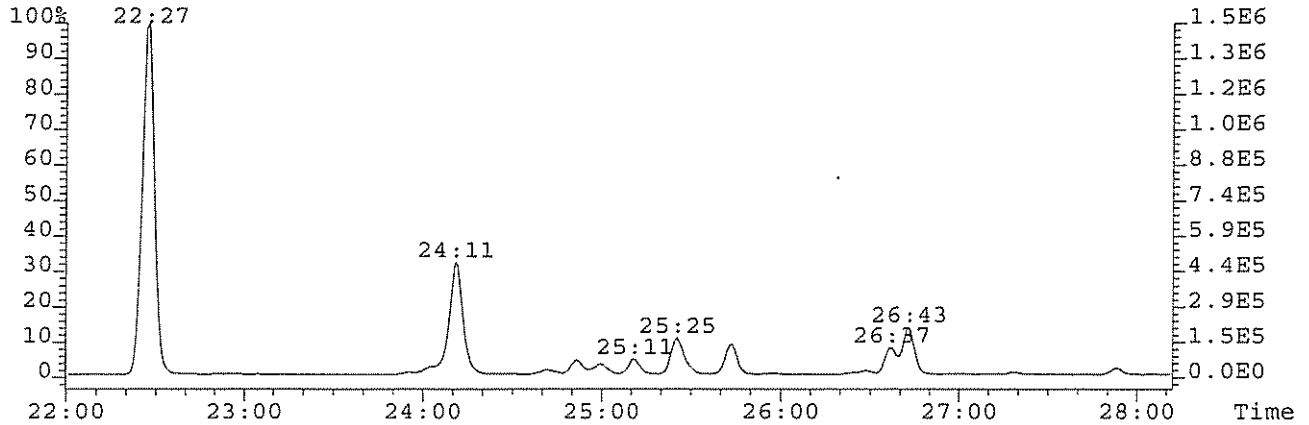
333.9339 S:11 SMO(1,3)



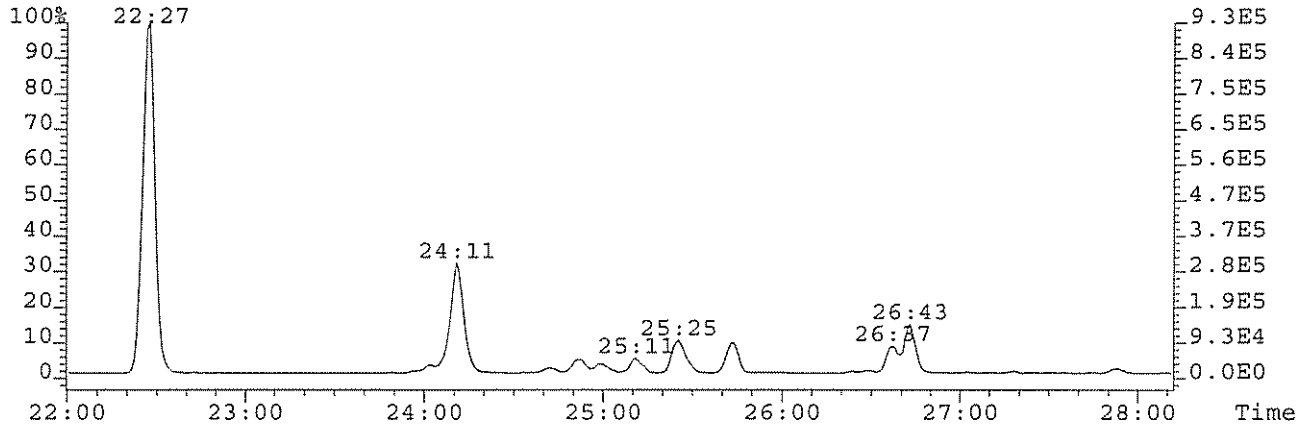
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130712-2 #1-1578 Acq:13-JUL-2013 00:40:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:BPX-DXN(4-6DXN) Text:XE13 0954 Exp:BPX04

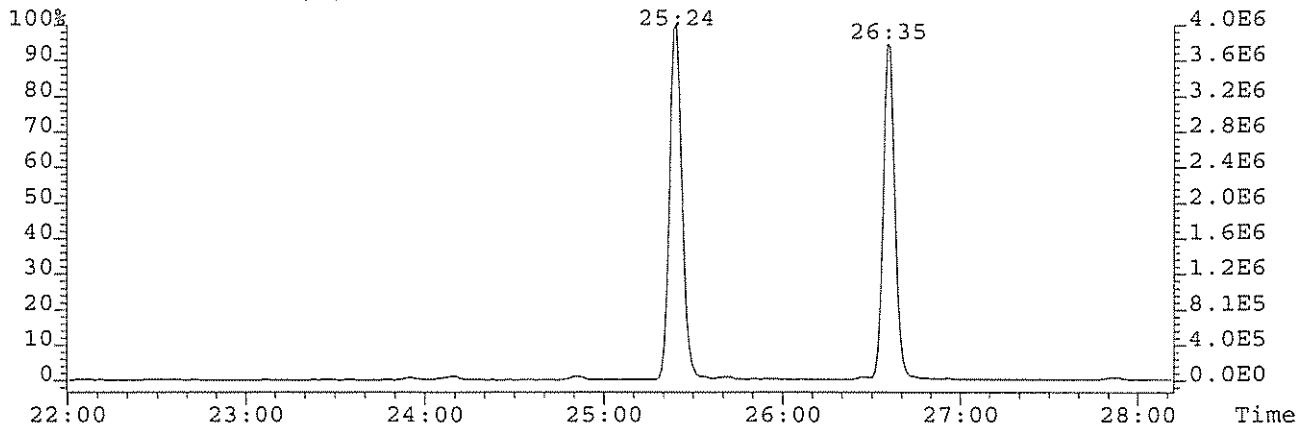
339.8597 S:11 SMO(1,3)



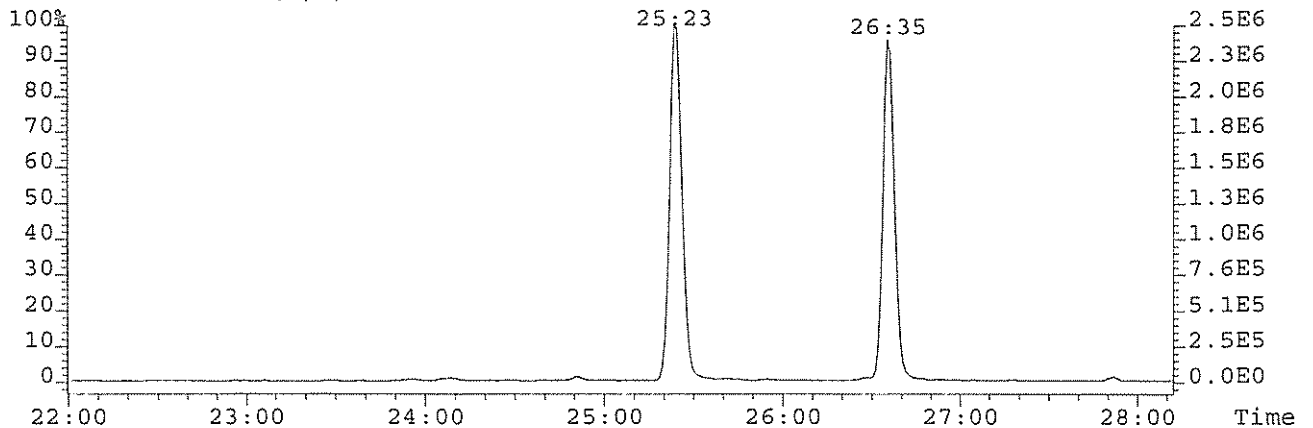
341.8568 S:11 SMO(1,3)



351.9000 S:11 SMO(1,3)



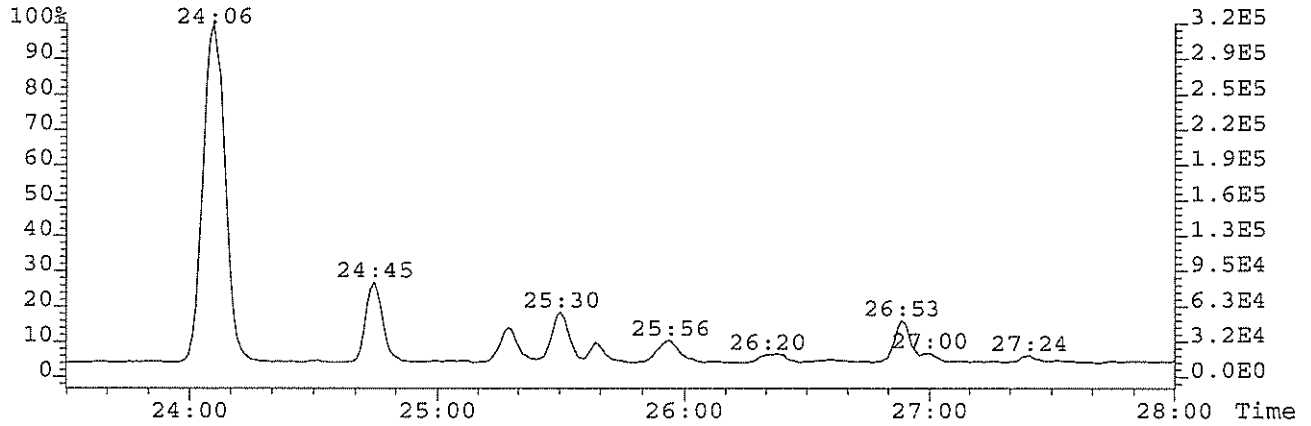
353.8970 S:11 SMO(1,3)



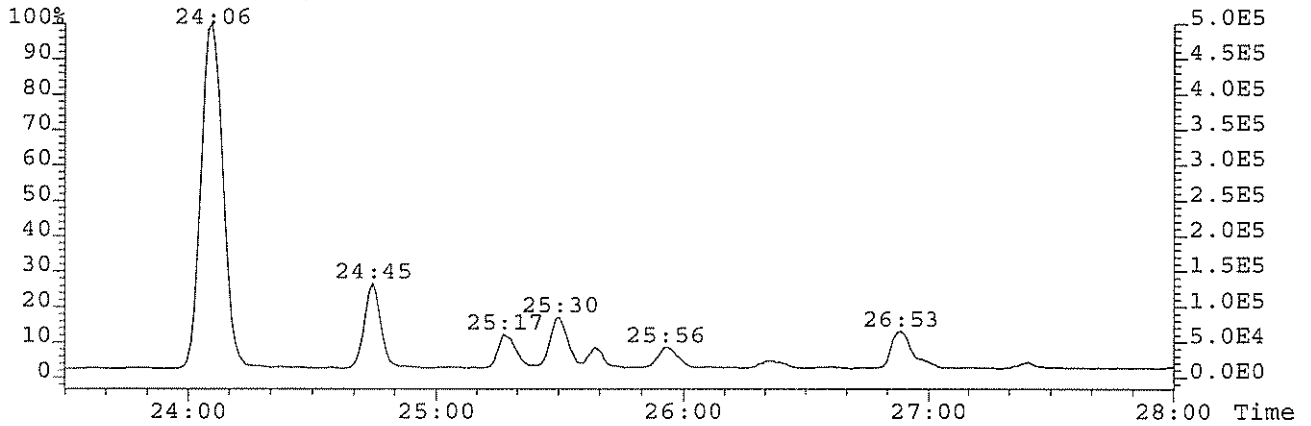
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 00:40:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:BPX-DXN(4-6DXN) Text:XE13 0954 Exp:BPX04

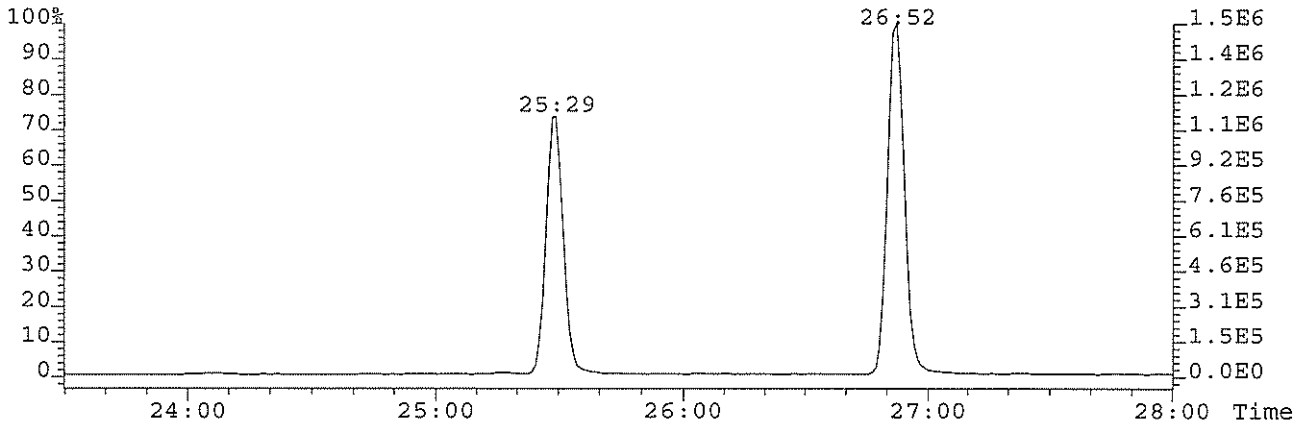
353.8576 S:11 SMO(1,3)



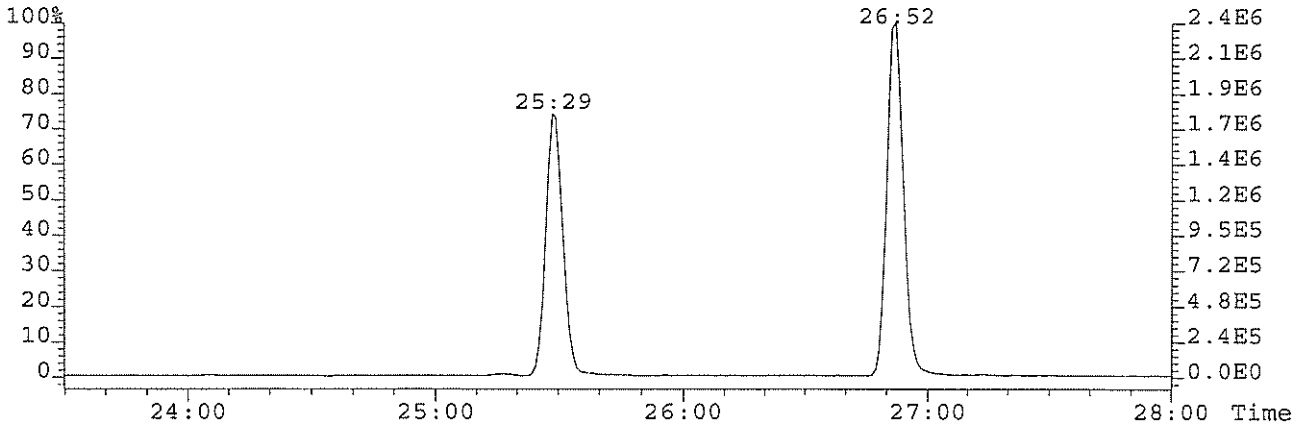
355.8546 S:11 SMO(1,3)



365.8978 S:11 SMO(1,3)



367.8949 S:11 SMO(1,3)

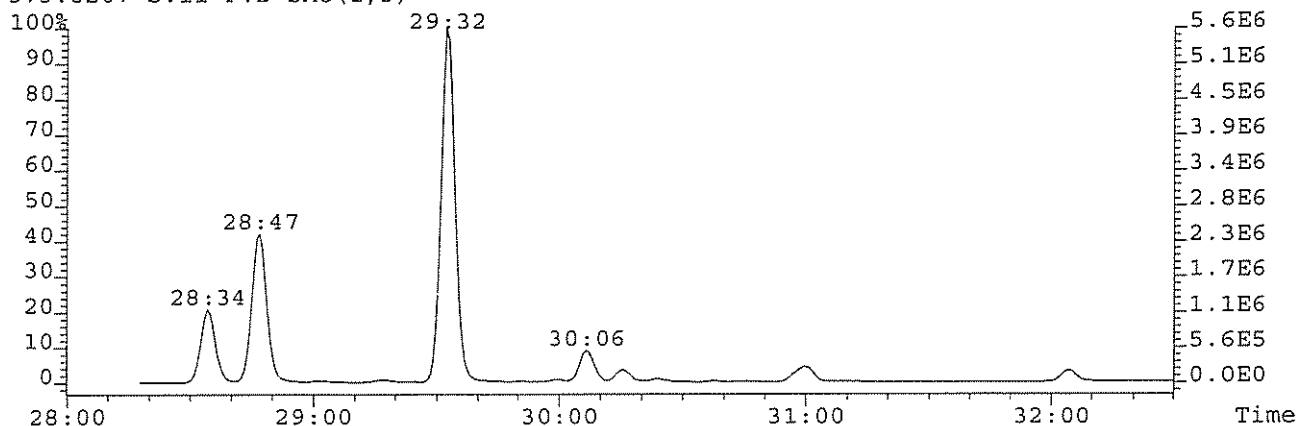


PCDDsクロマトグラム (4)  
(PeCDDs)

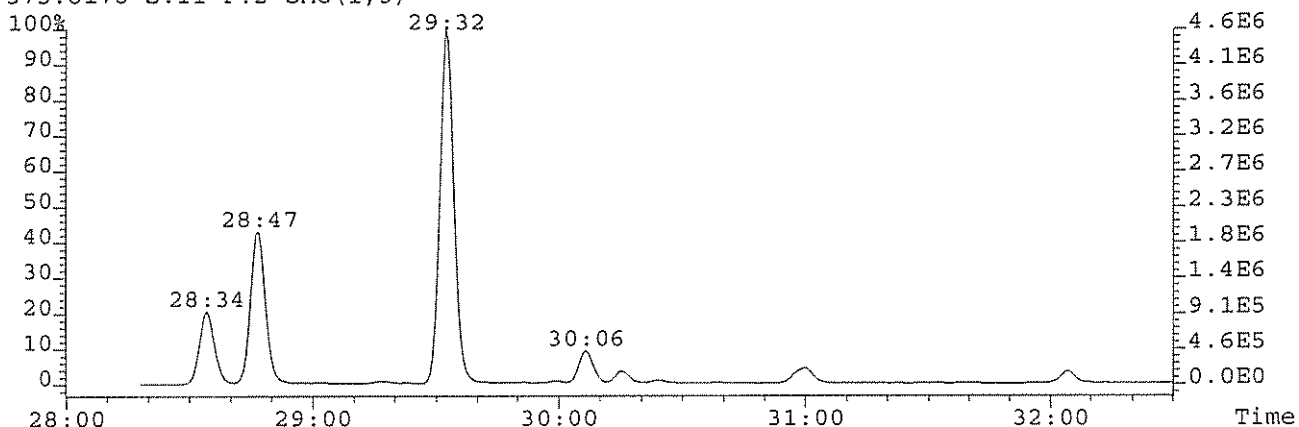


File:130712-2 #1-1117 Acq:13-JUL-2013 00:40:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:BPX-DXN(4-6DXN) Text:XE13 0954 Exp:BPX04

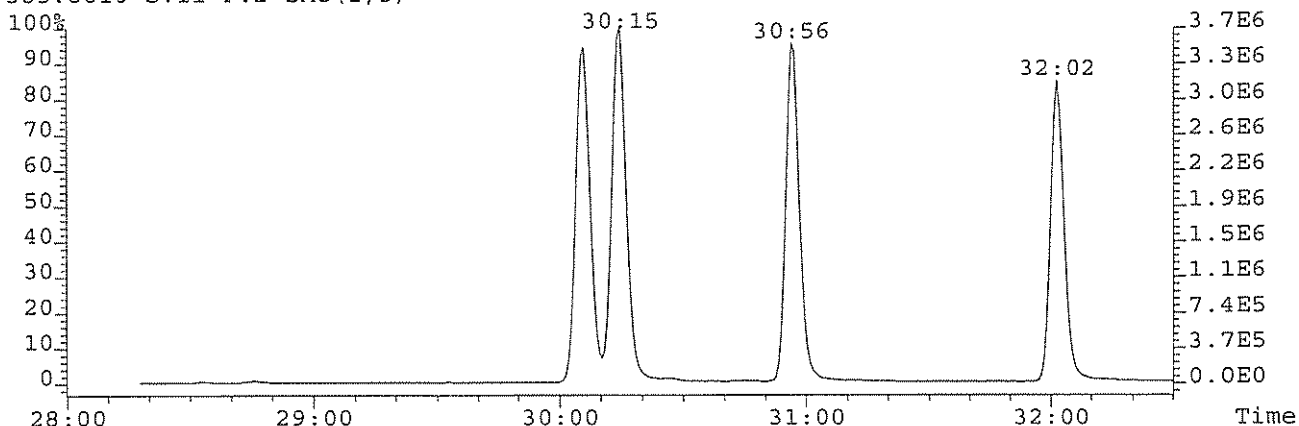
373.8207 S:11 F:2 SMO(1,3)



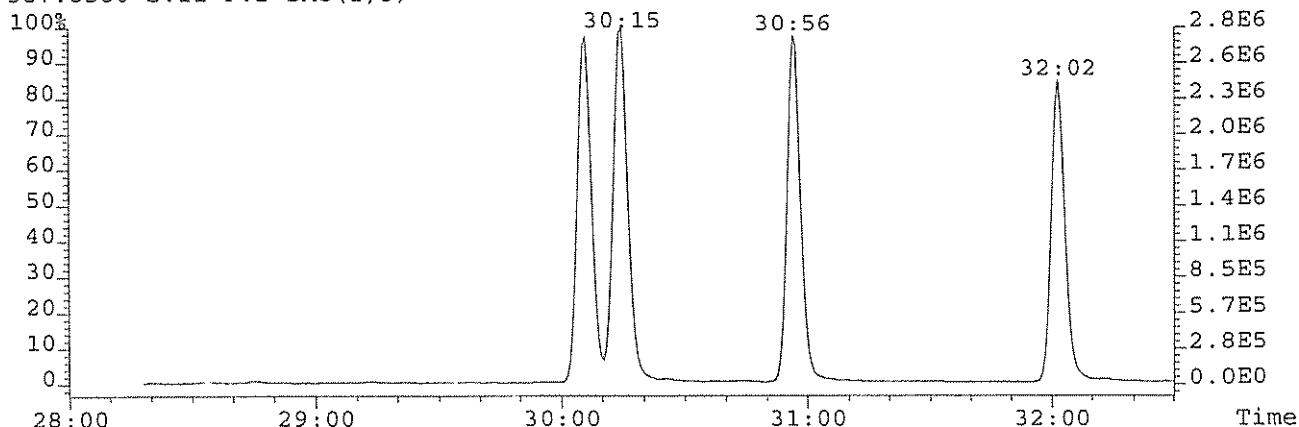
375.8178 S:11 F:2 SMO(1,3)



385.8610 S:11 F:2 SMO(1,3)



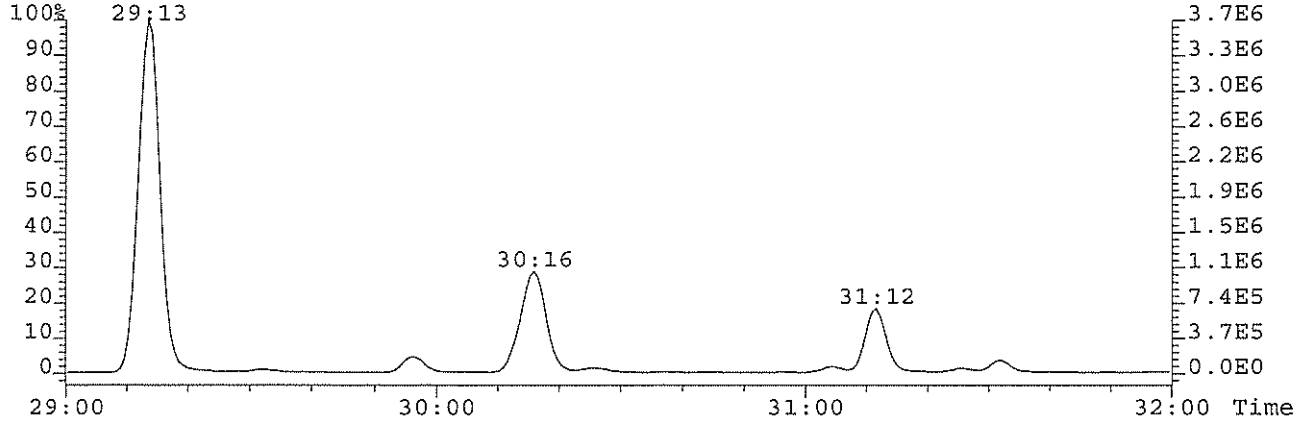
387.8580 S:11 F:2 SMO(1,3)



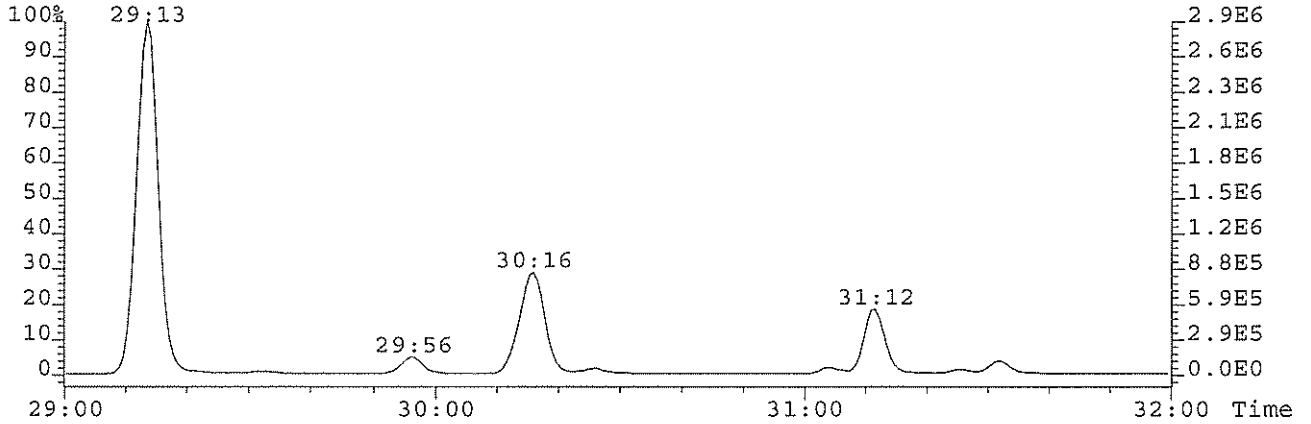
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1117 Acq:13-JUL-2013 00:40:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:BPX-DXN(4-6DXN) Text:XE13 0954 Exp:BPX04

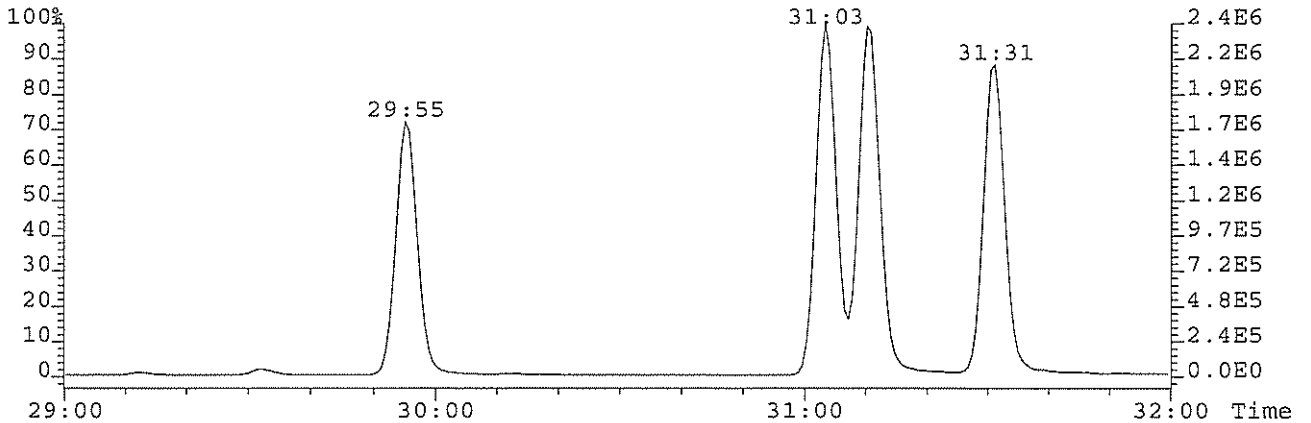
389.8156 S:11 F:2 SMO(1,3)



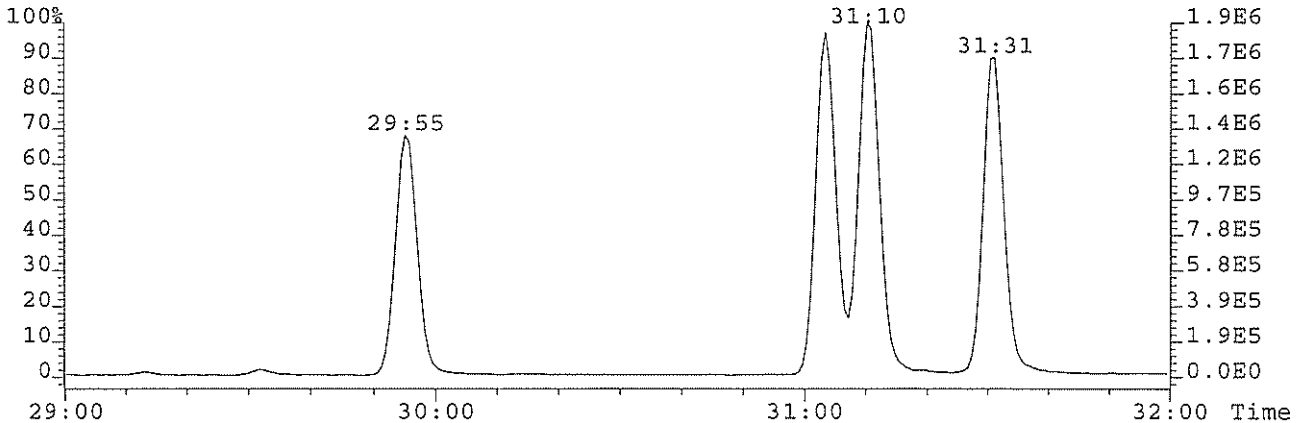
391.8127 S:11 F:2 SMO(1,3)



401.8559 S:11 F:2 SMO(1,3)

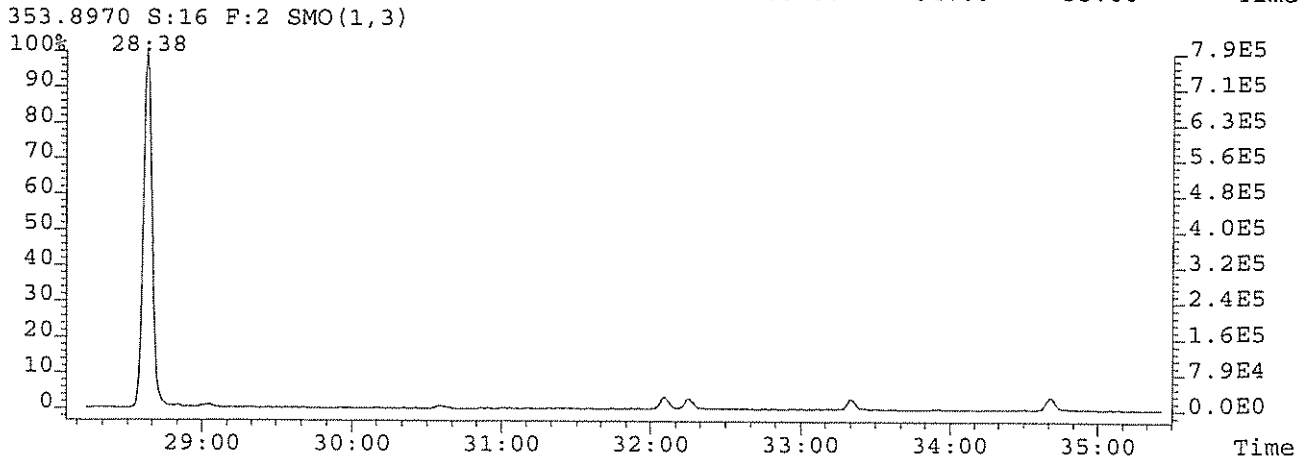
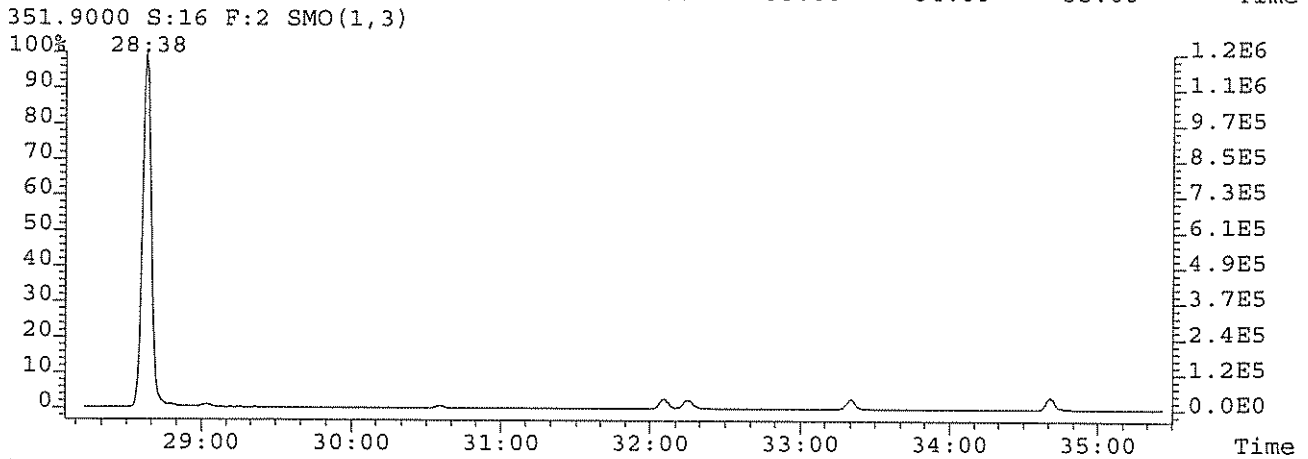
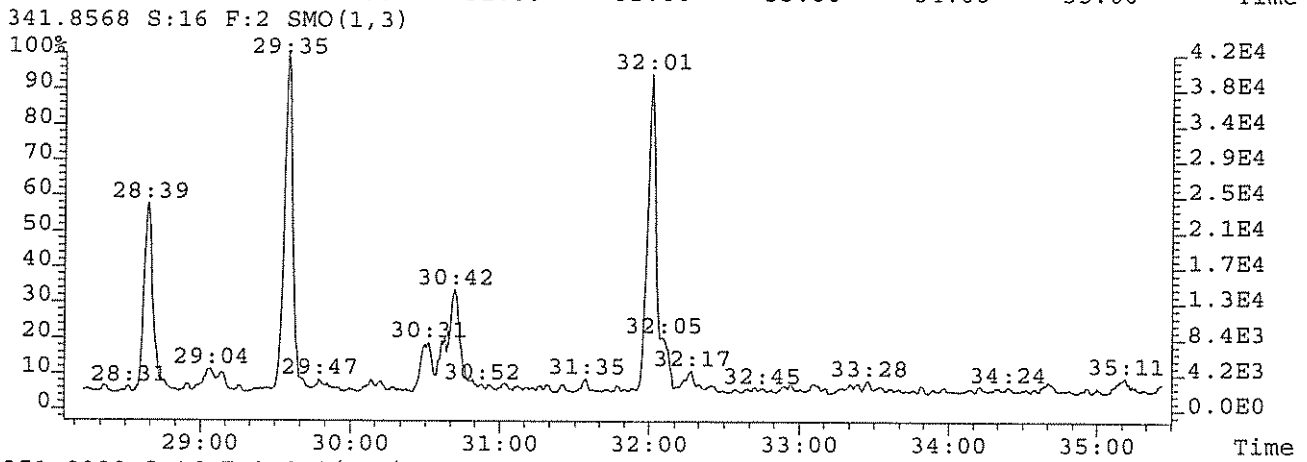
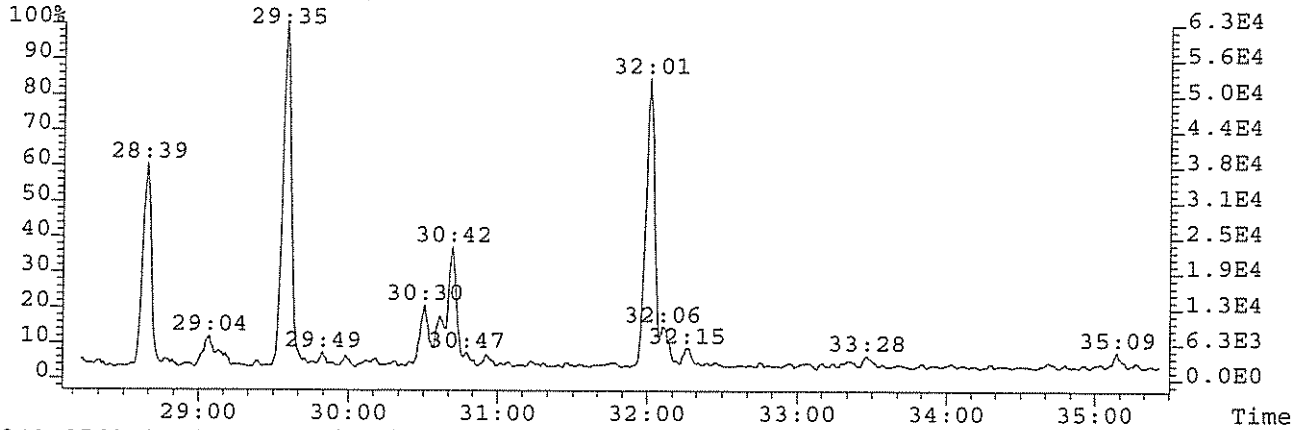


403.8530 S:11 F:2 SMO(1,3)

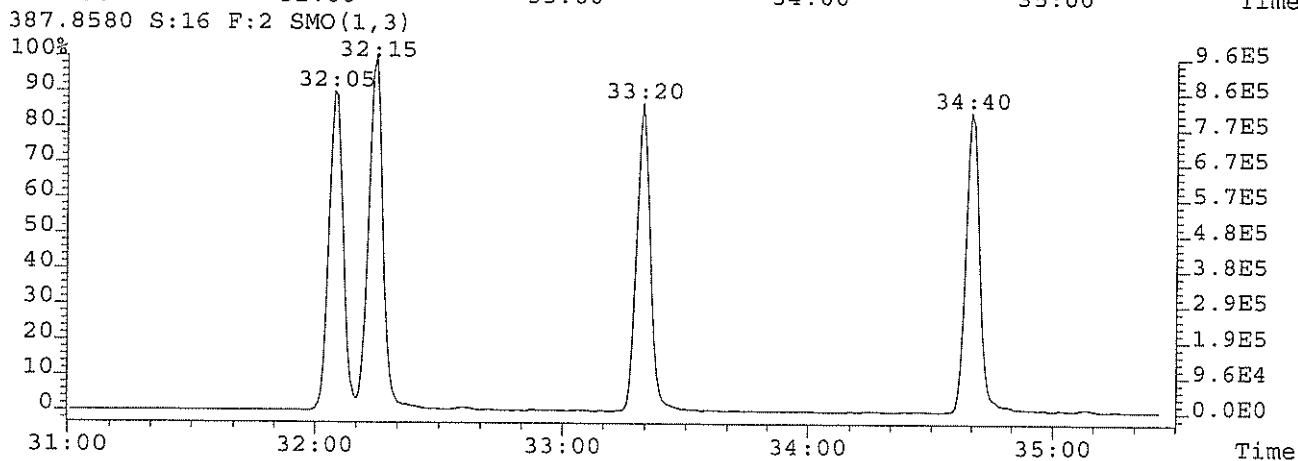
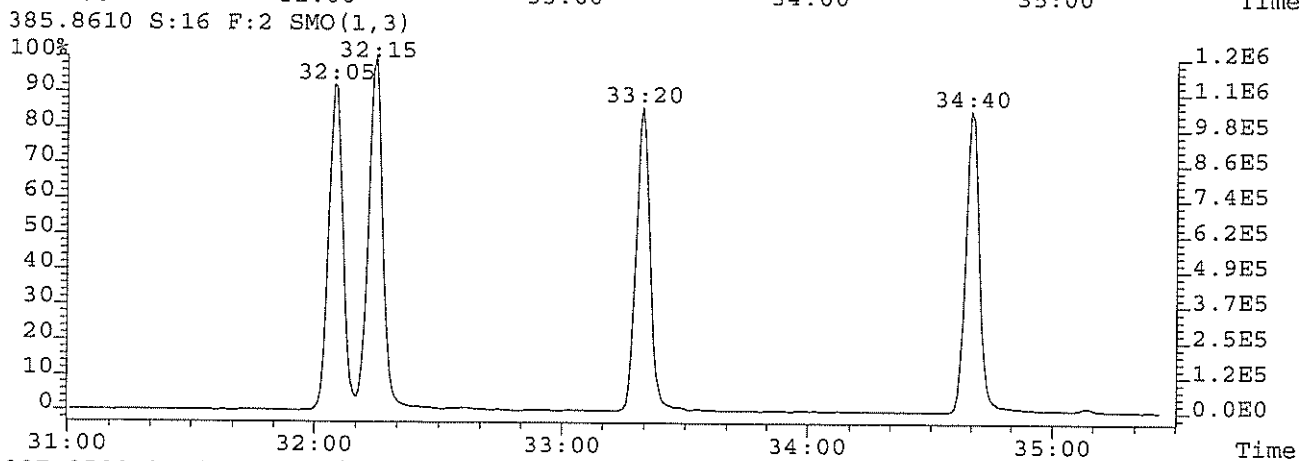
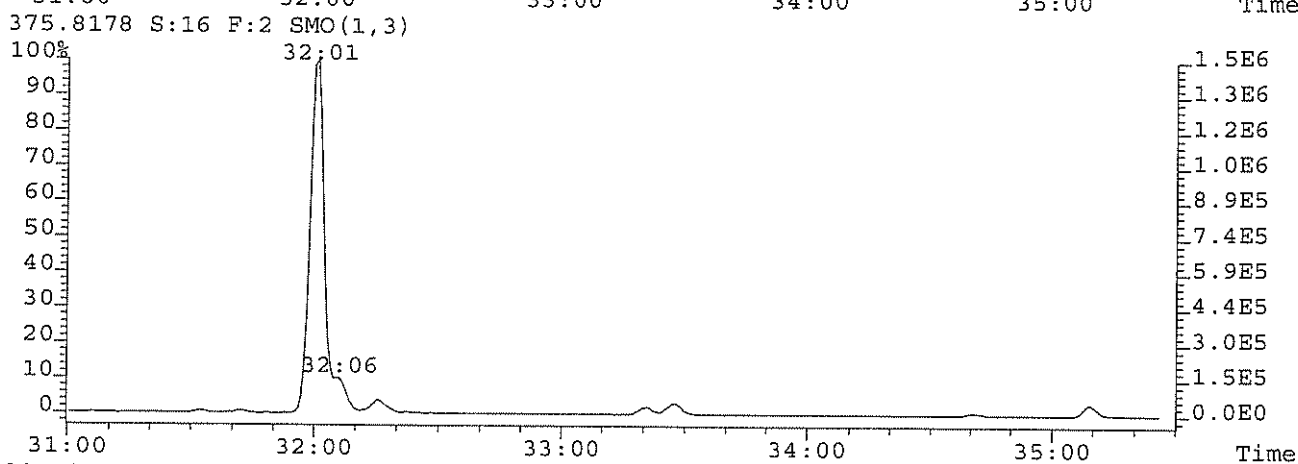
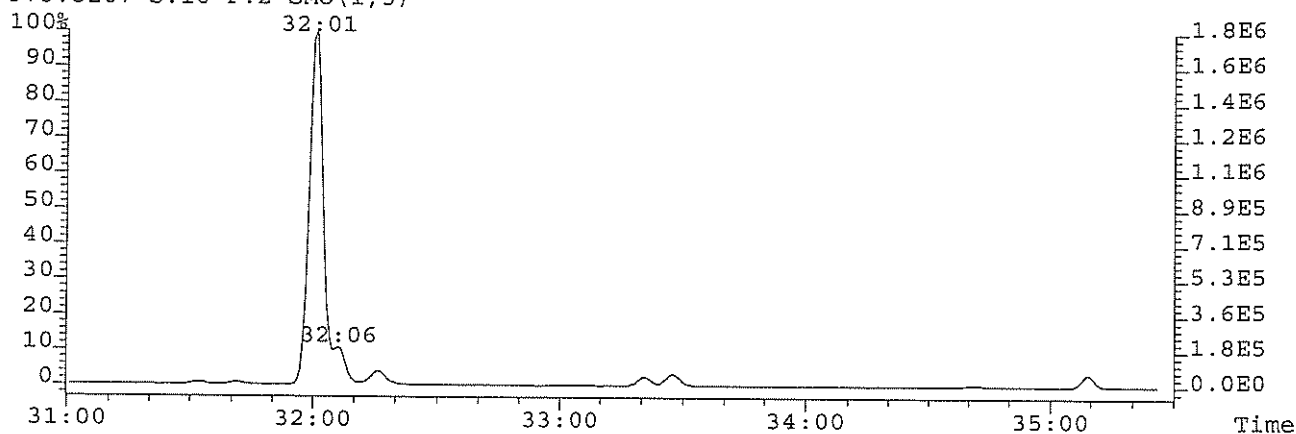


PCDDsクロマトグラム (6)  
(HxCDDs)

File:130711-2 #1-648 Acq:12-JUL-2013 07:15:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0954 3 Exp:RH-PD22

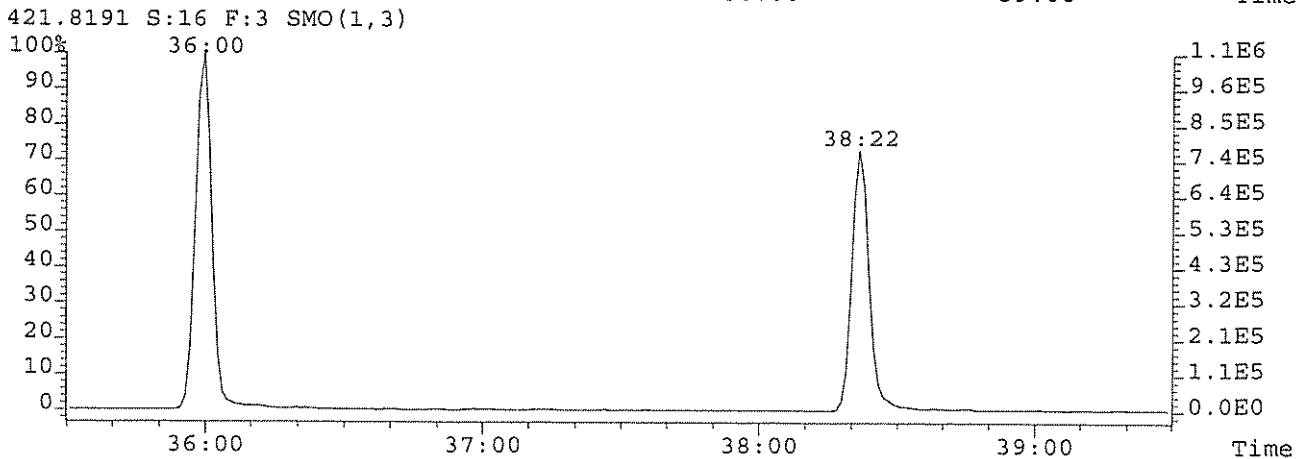
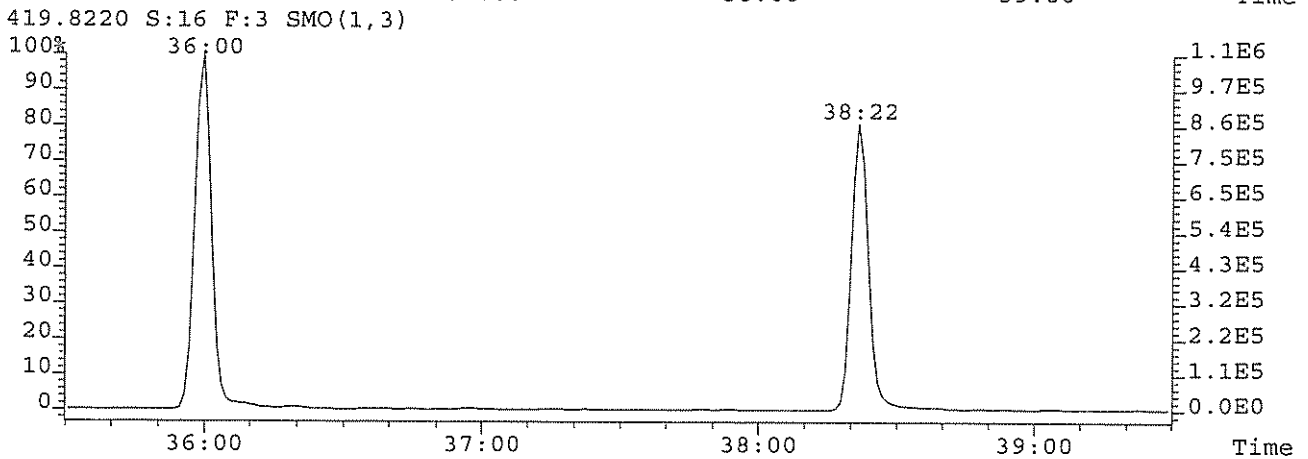
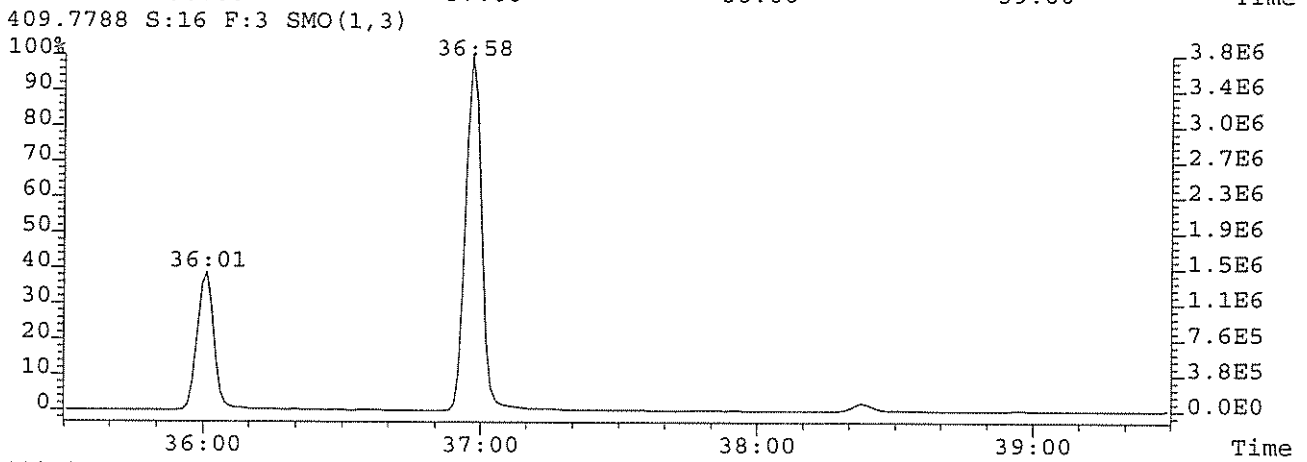
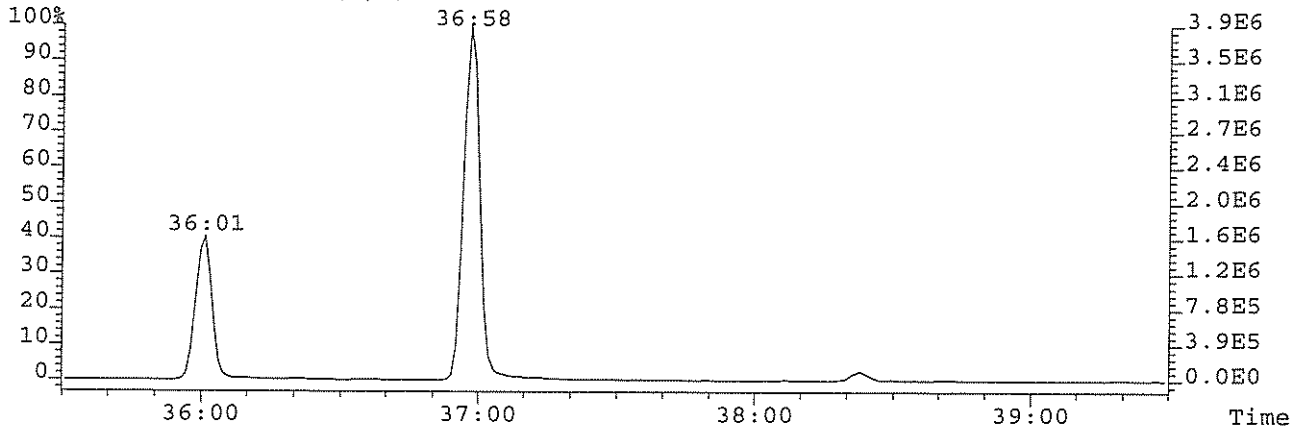


File:130711-2 #1-648 Acq:12-JUL-2013 07:15:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0954 3 Exp:RH-PD22



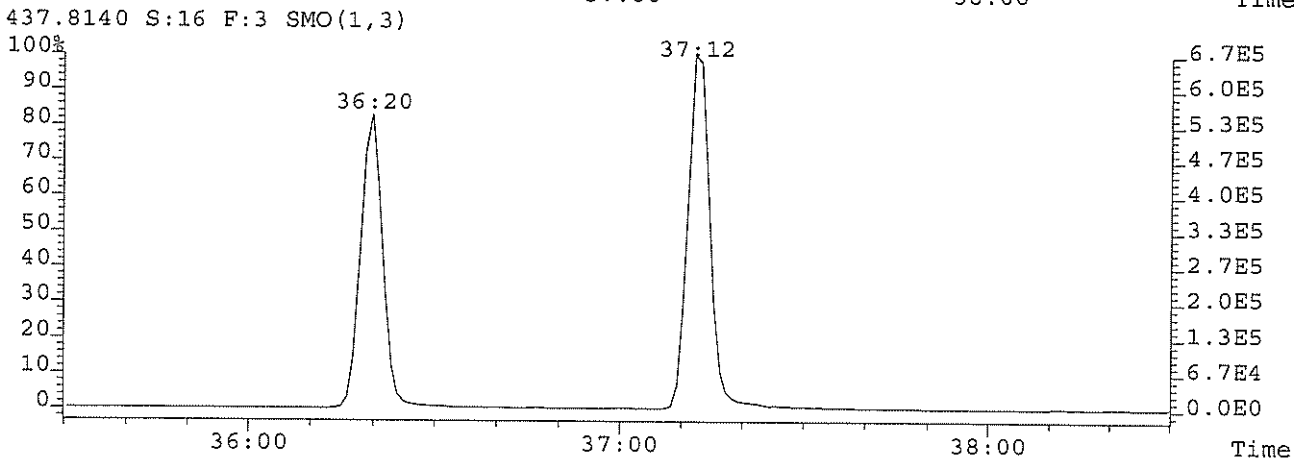
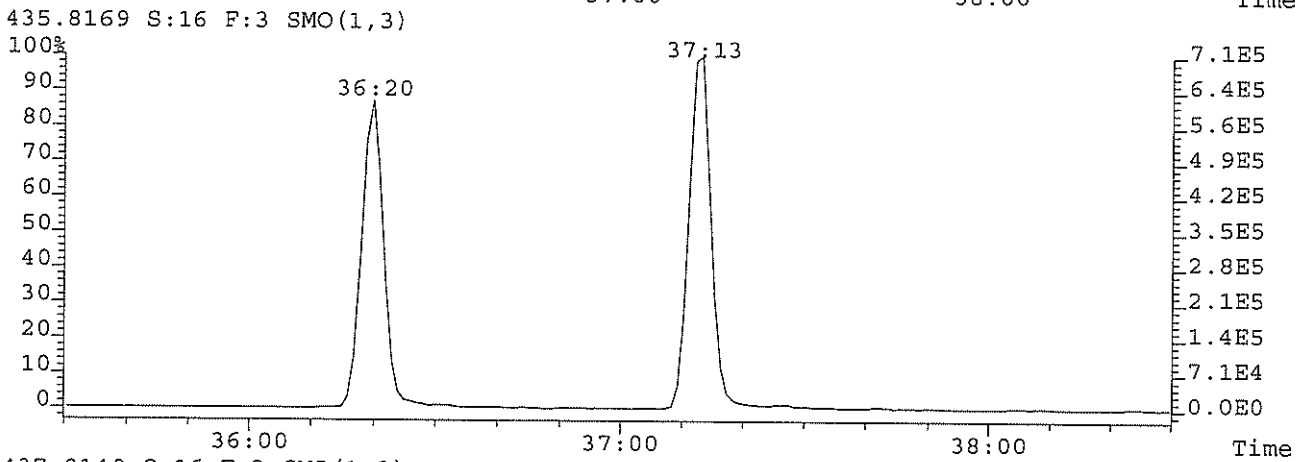
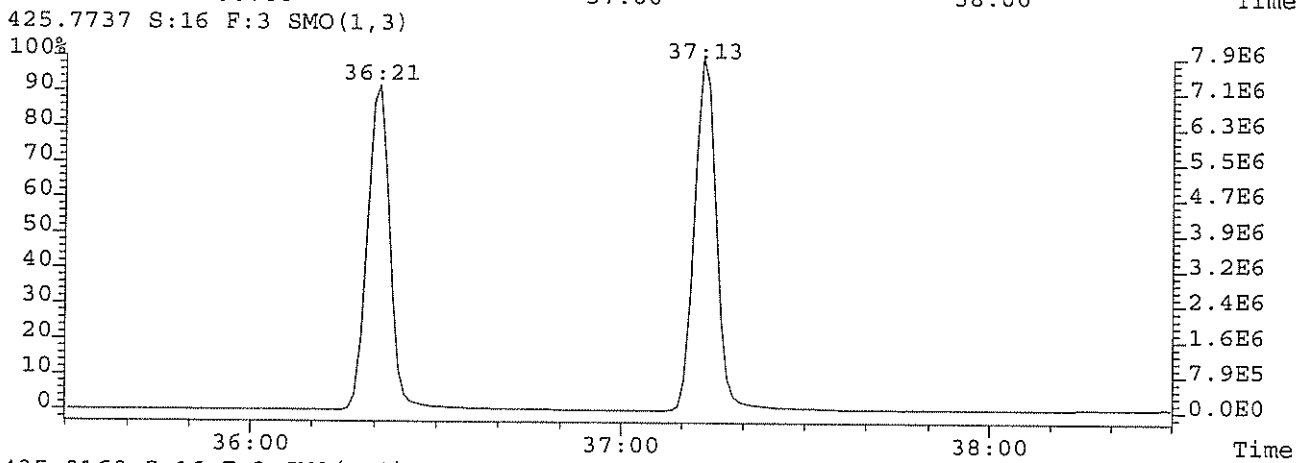
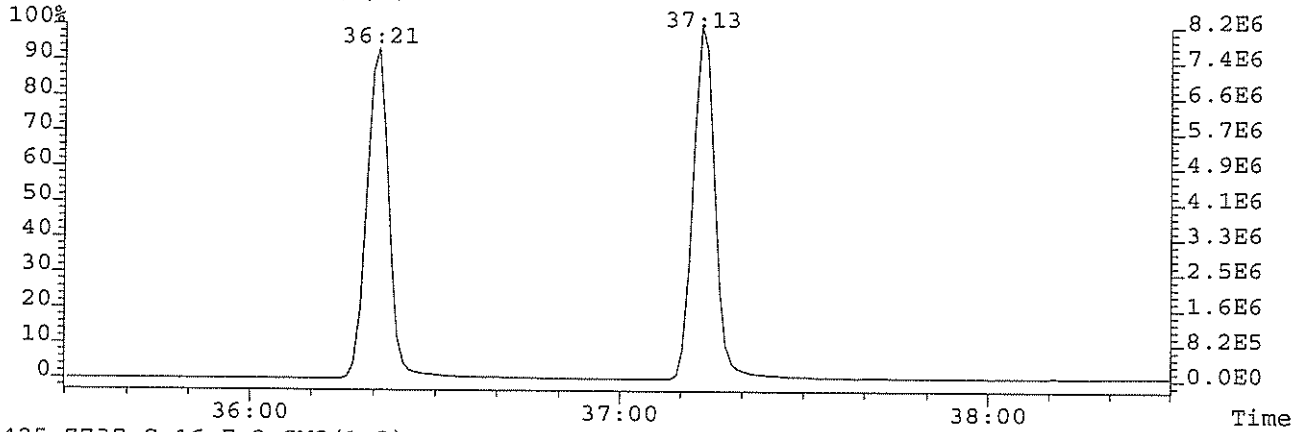
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130711-2 #1-561 Acq:12-JUL-2013 07:15:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0954 3 Exp:RH-PD22  
407.7818 S:16 F:3 SMO(1,3)



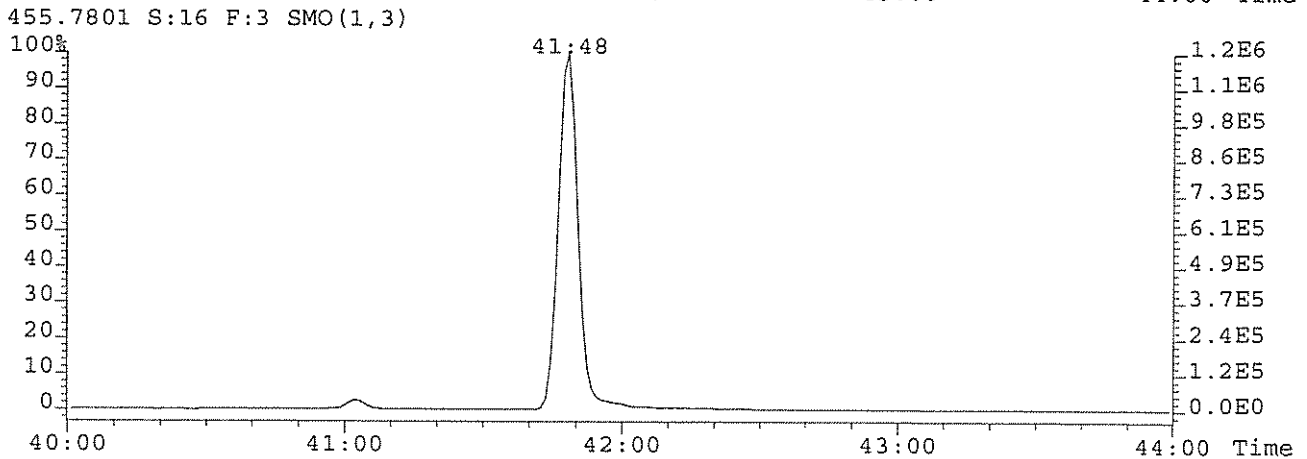
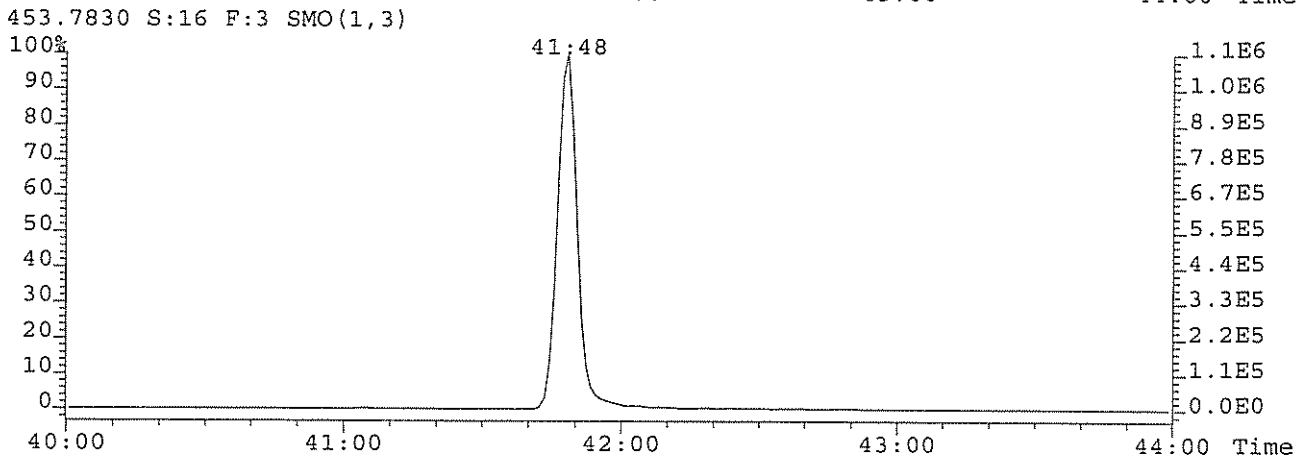
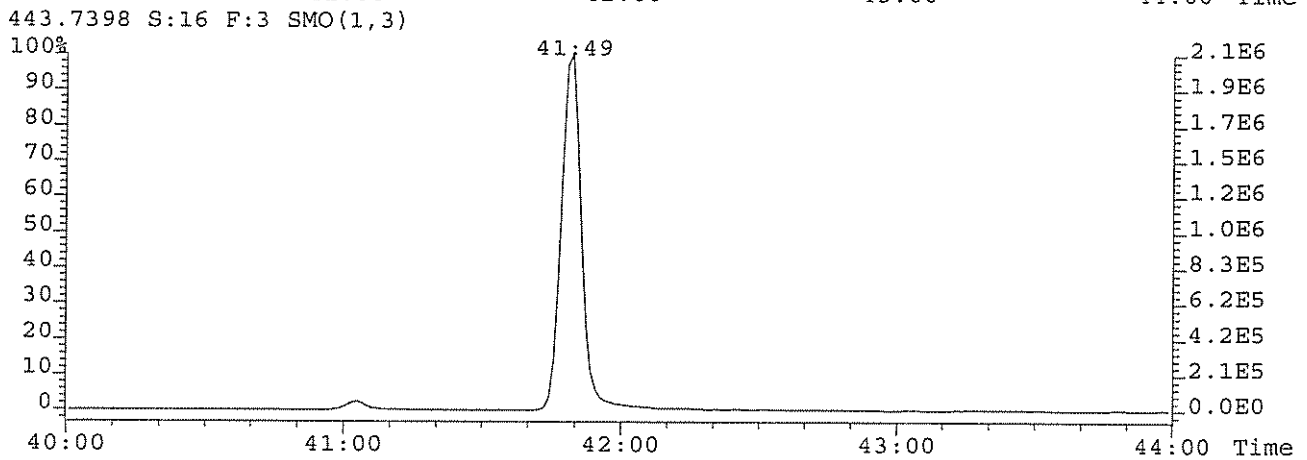
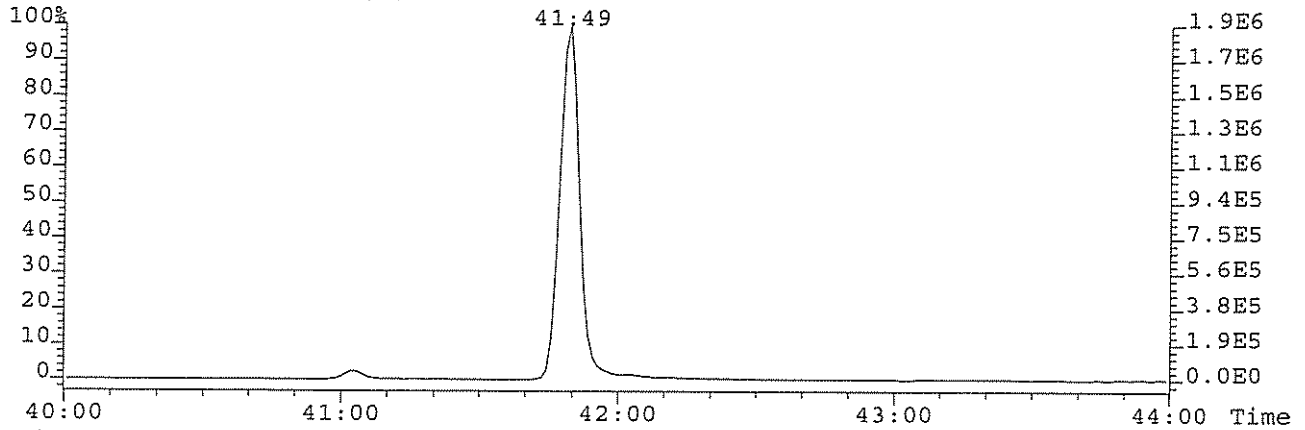
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130711-2 #1-561 Acq:12-JUL-2013 07:15:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0954 3 Exp:RH-PD22  
423.7767 S:16 F:3 SMO(1,3)

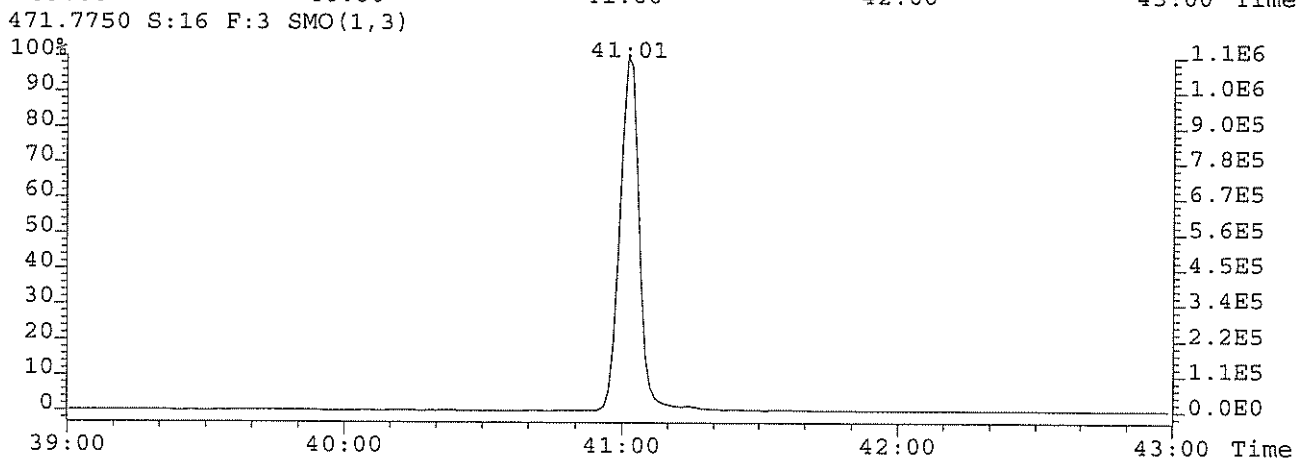
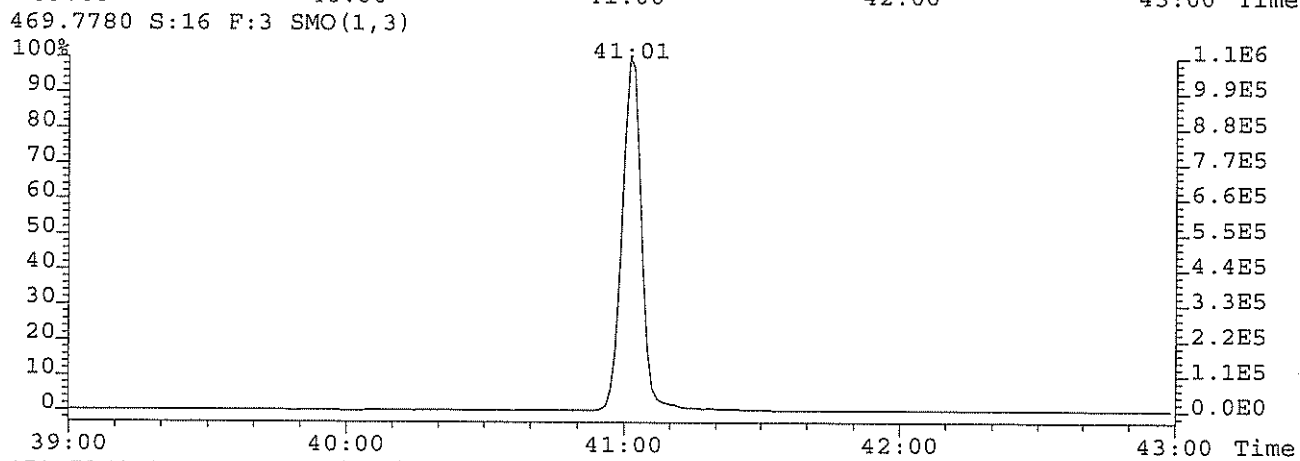
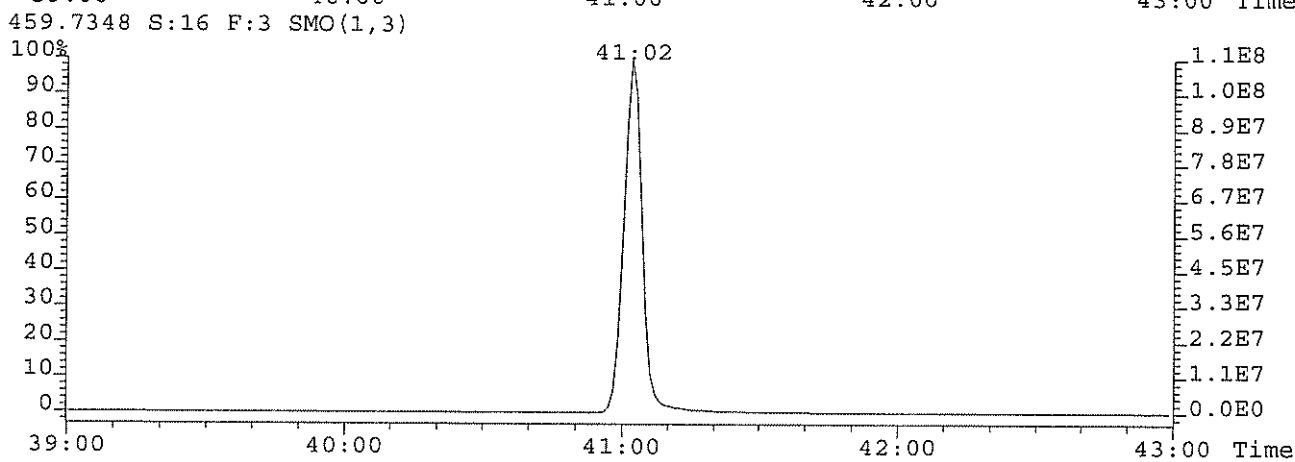
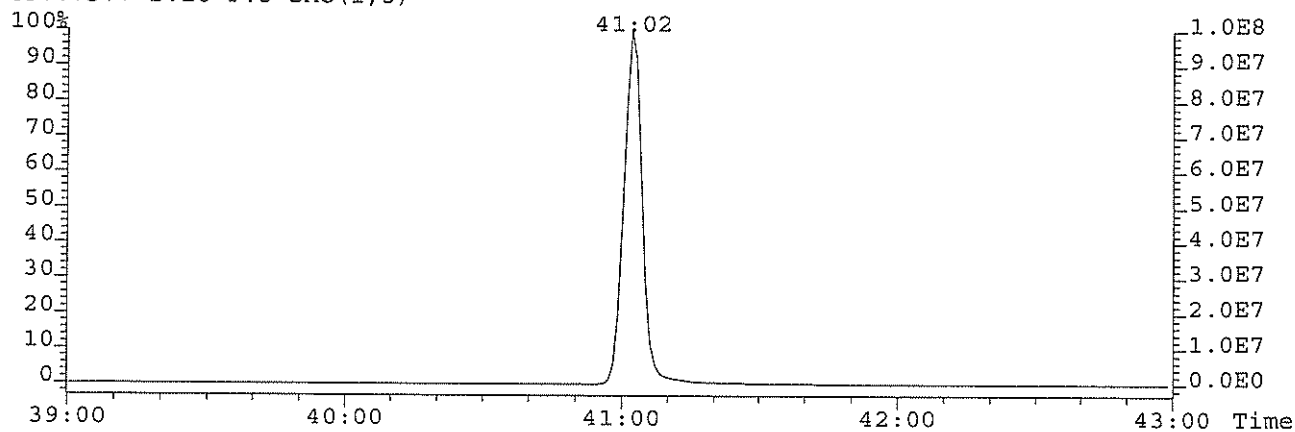


PCDDsクロマトグラム (10)  
(HpCDDs)

File:130711-2 #1-561 Acq:12-JUL-2013 07:15:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0954 3 Exp:RH-PD22  
441.7428 S:16 F:3 SMO(1,3)



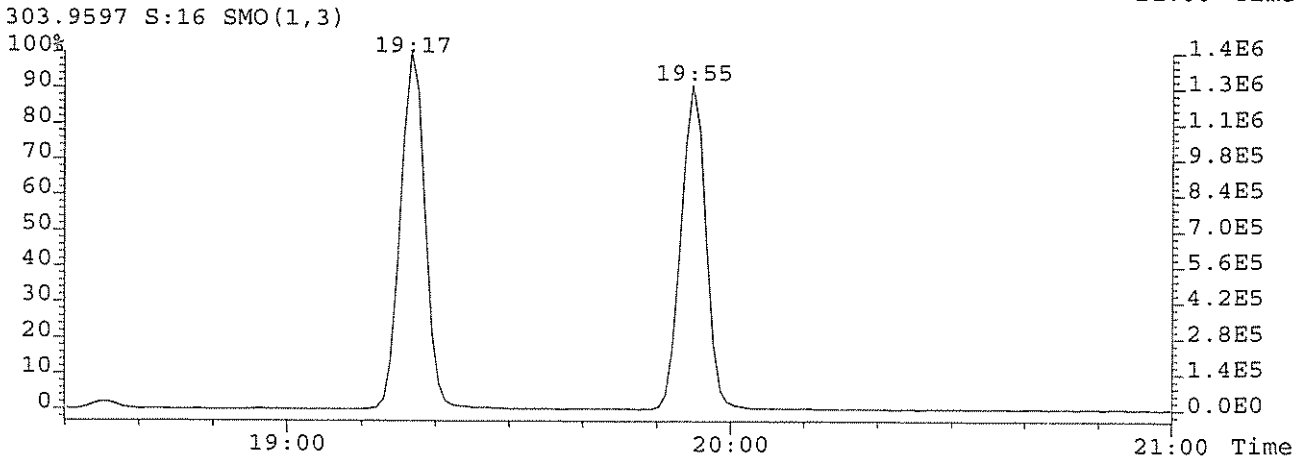
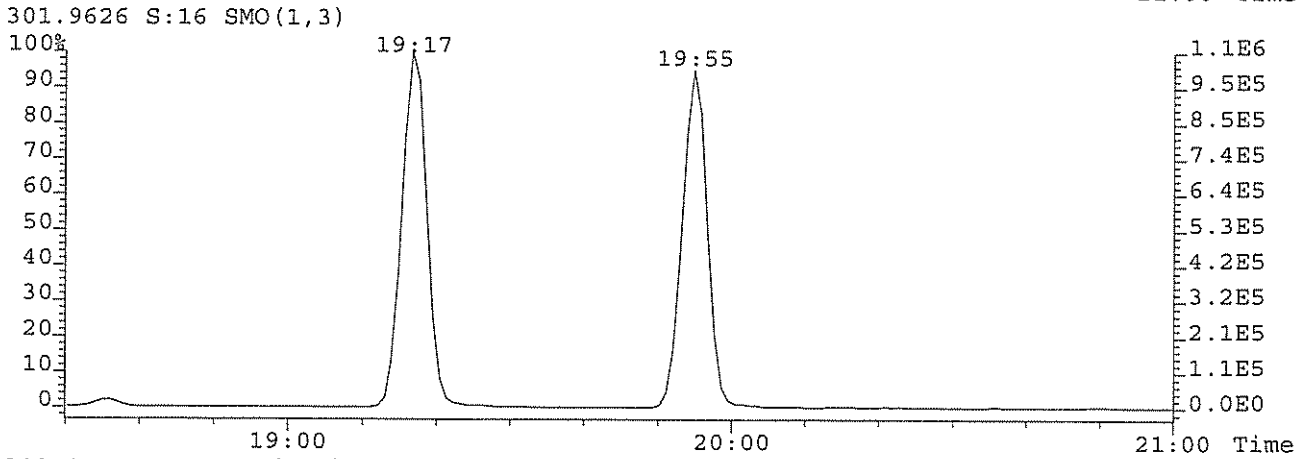
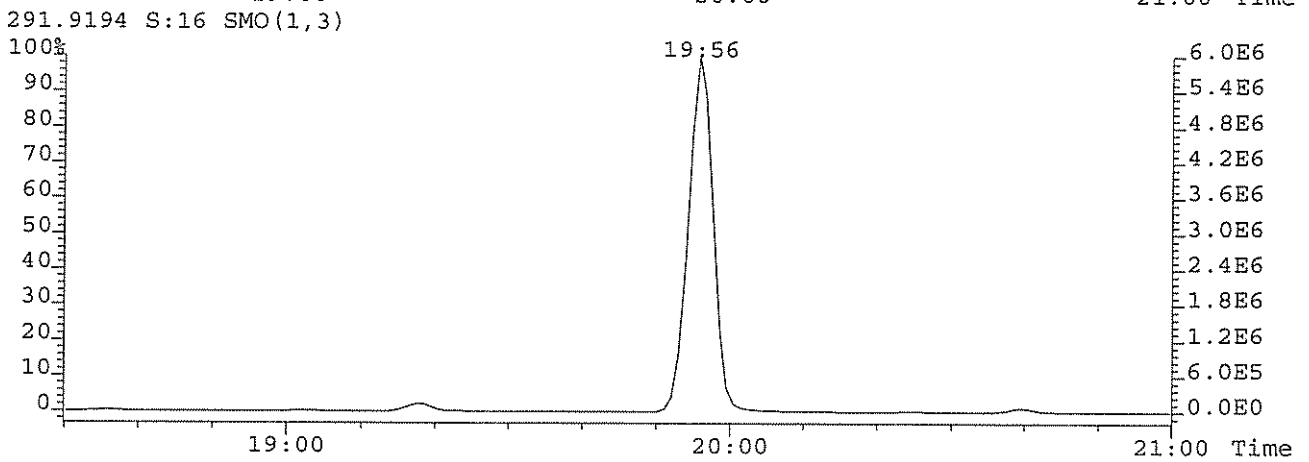
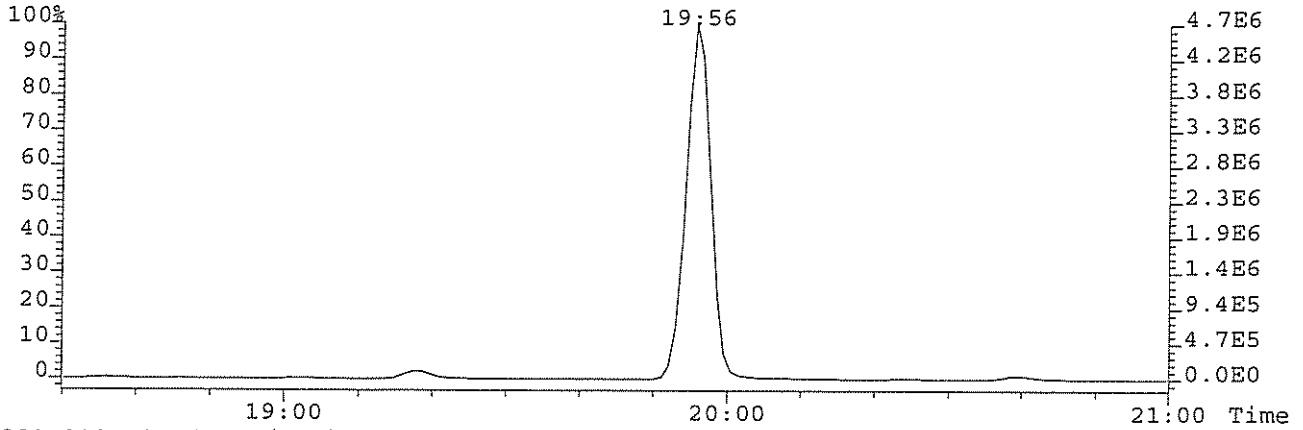
File:130711-2 #1-561 Acq:12-JUL-2013 07:15:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0954 3 Exp:RH-PD22



PCDDsクロマトグラム (12)  
(OCDD)



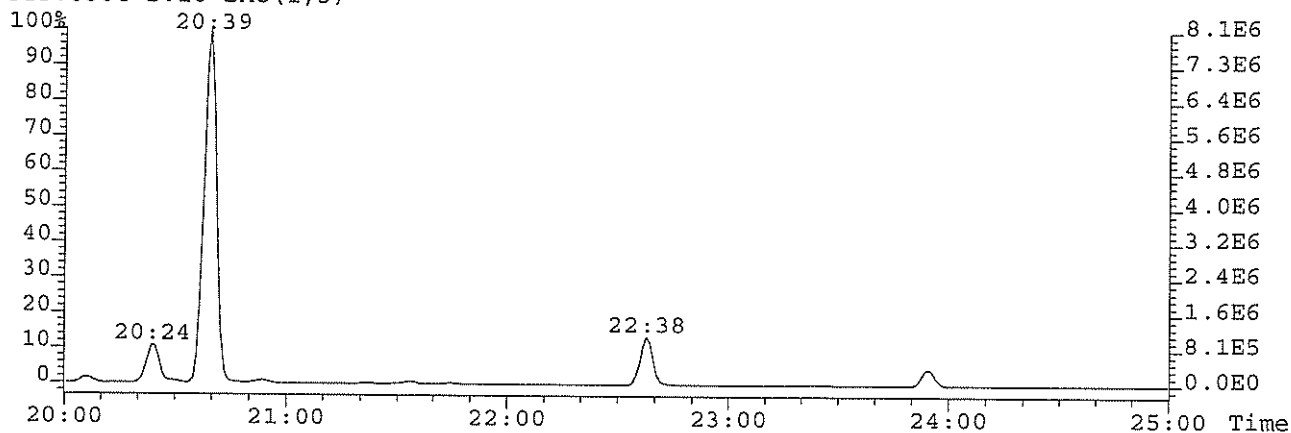
File:130711-2 #1-1430 Acq:12-JUL-2013 07:15:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0954 3 Exp:RH-PD22  
289.9224 S:16 SMO(1,3)



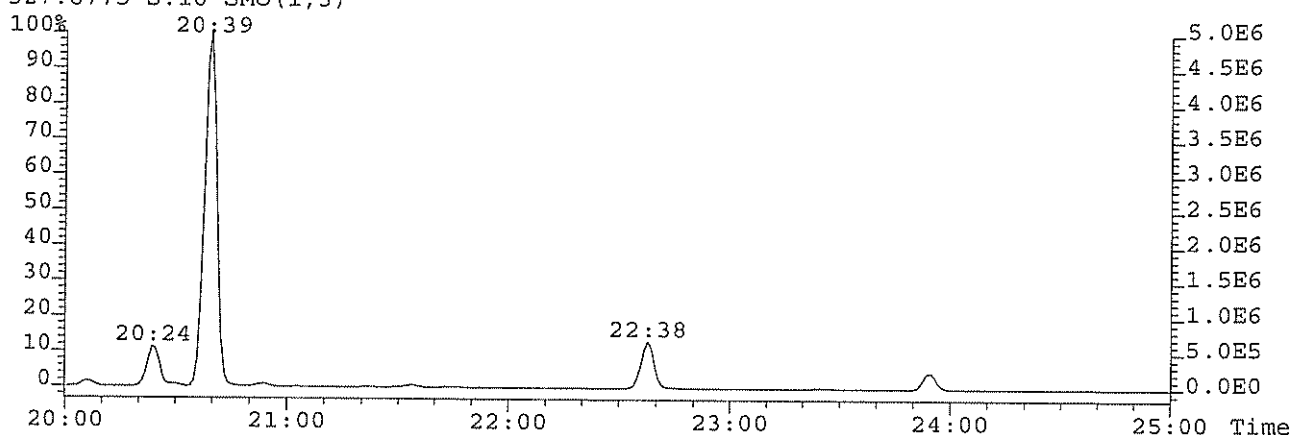
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 07:15:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0954 3 Exp:RH-PD22

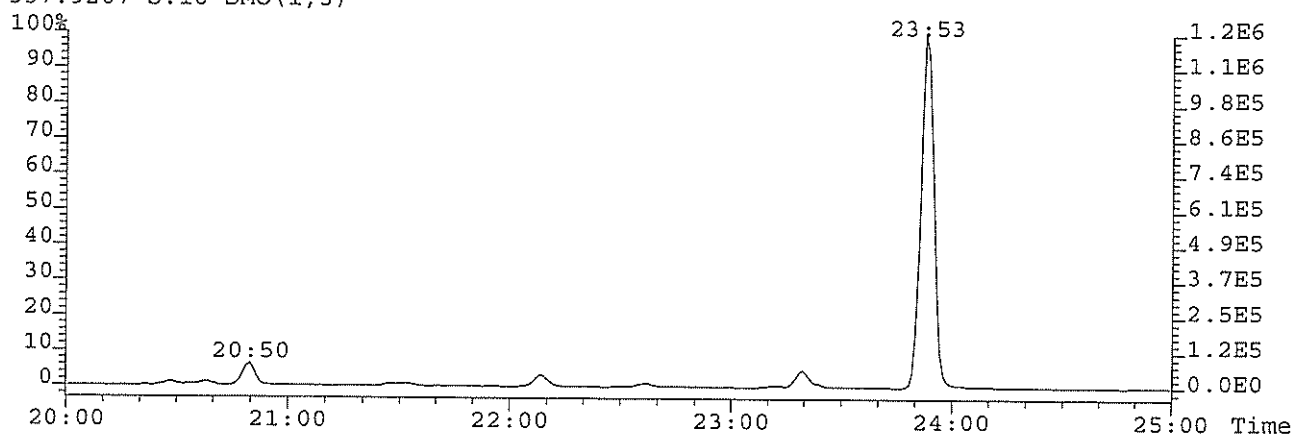
325.8804 S:16 SMO(1,3)



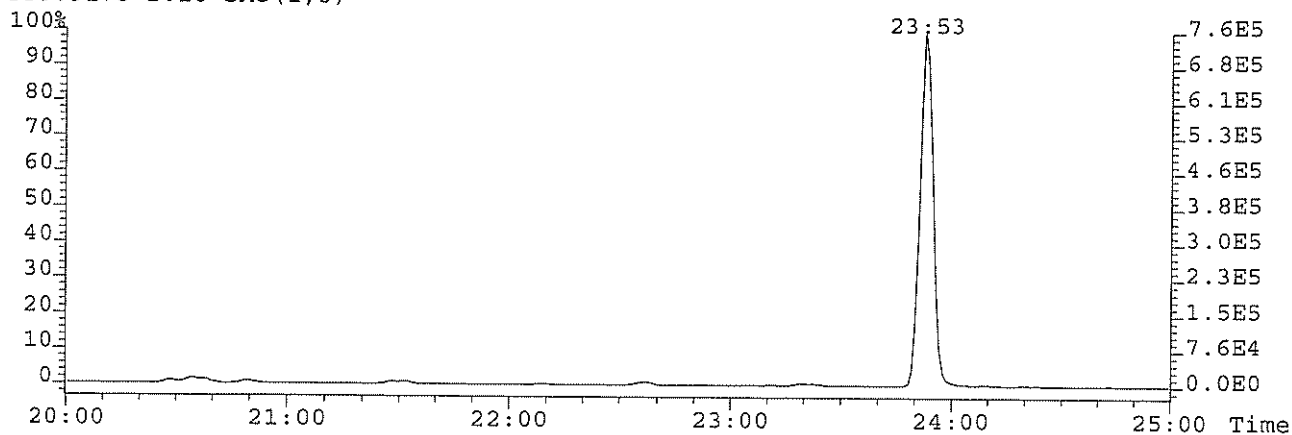
327.8775 S:16 SMO(1,3)



337.9207 S:16 SMO(1,3)

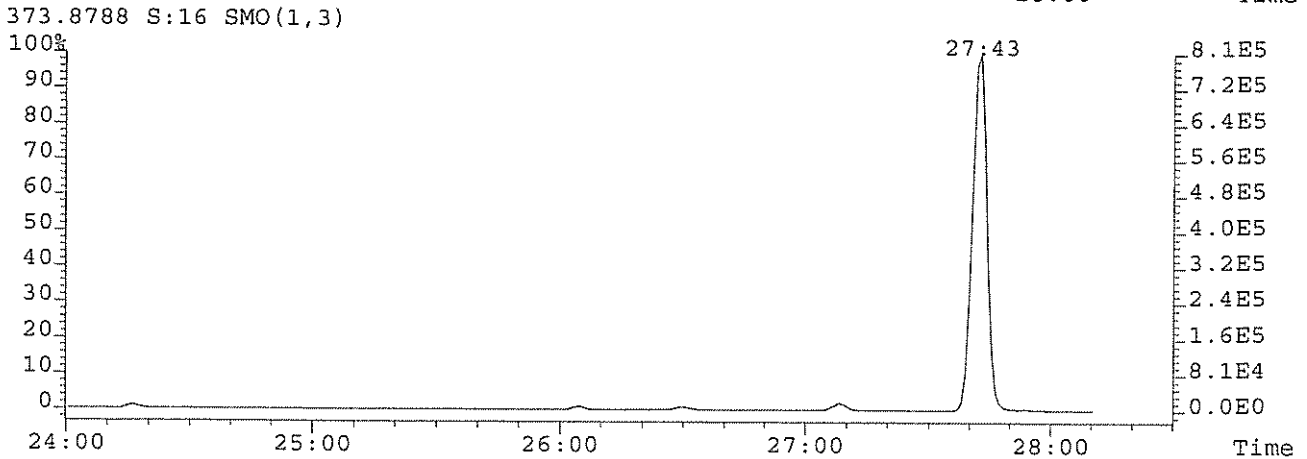
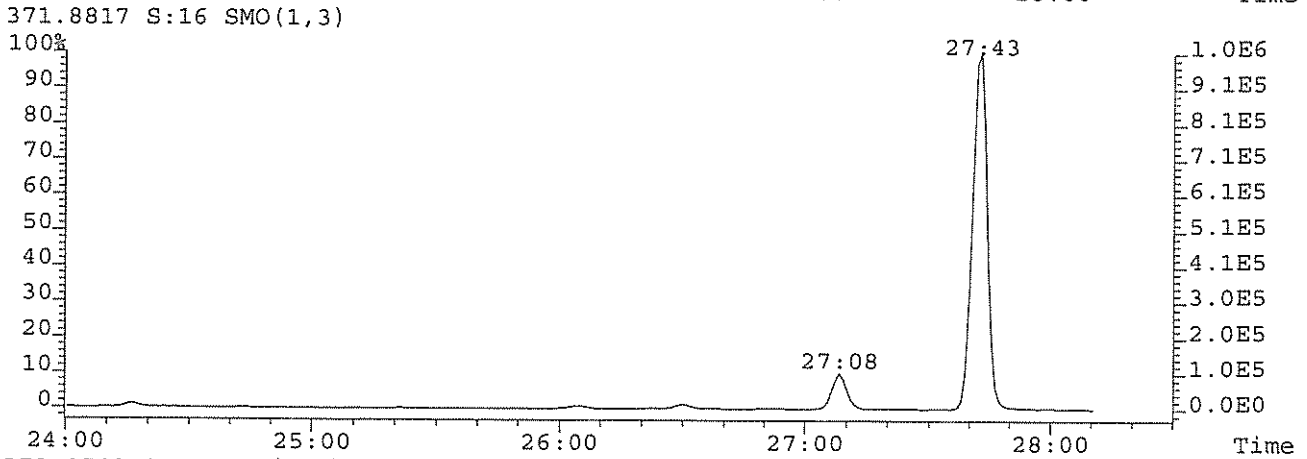
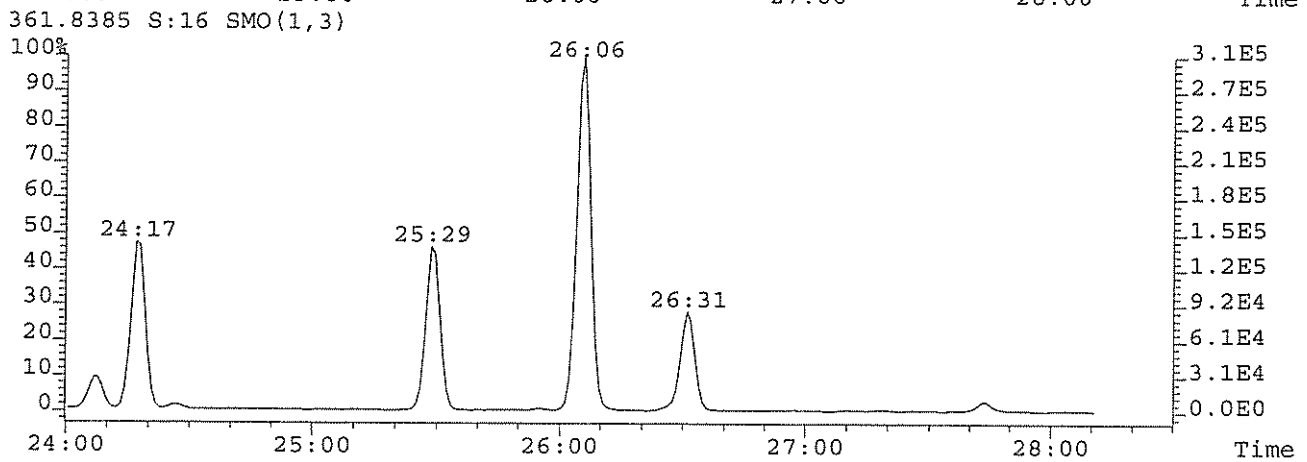
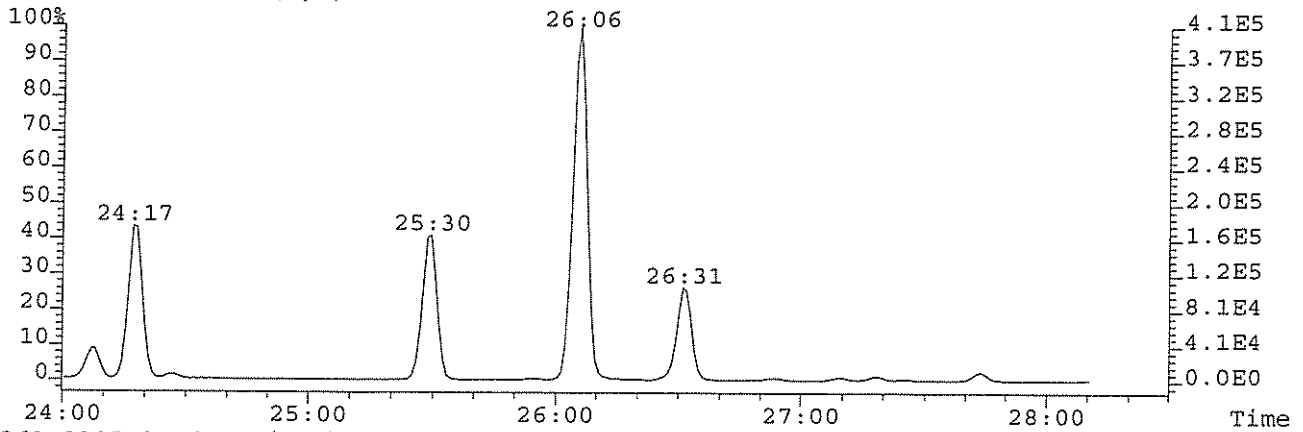


339.9178 S:16 SMO(1,3)



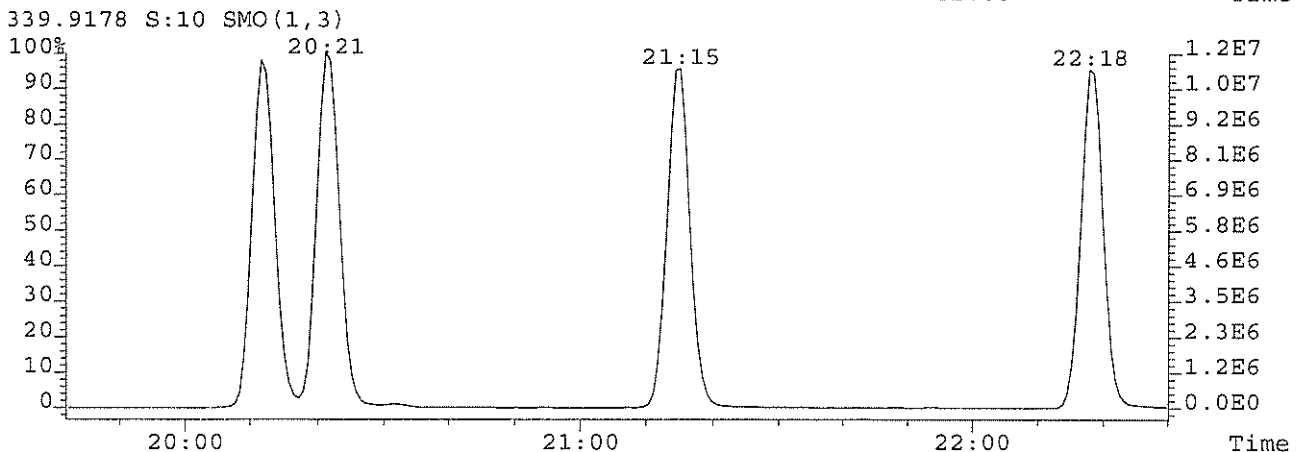
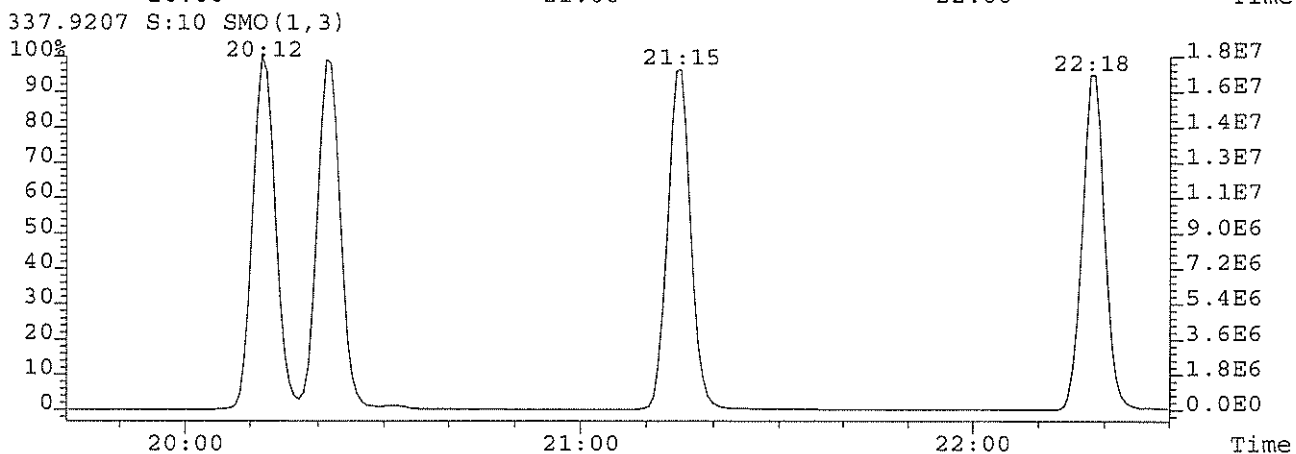
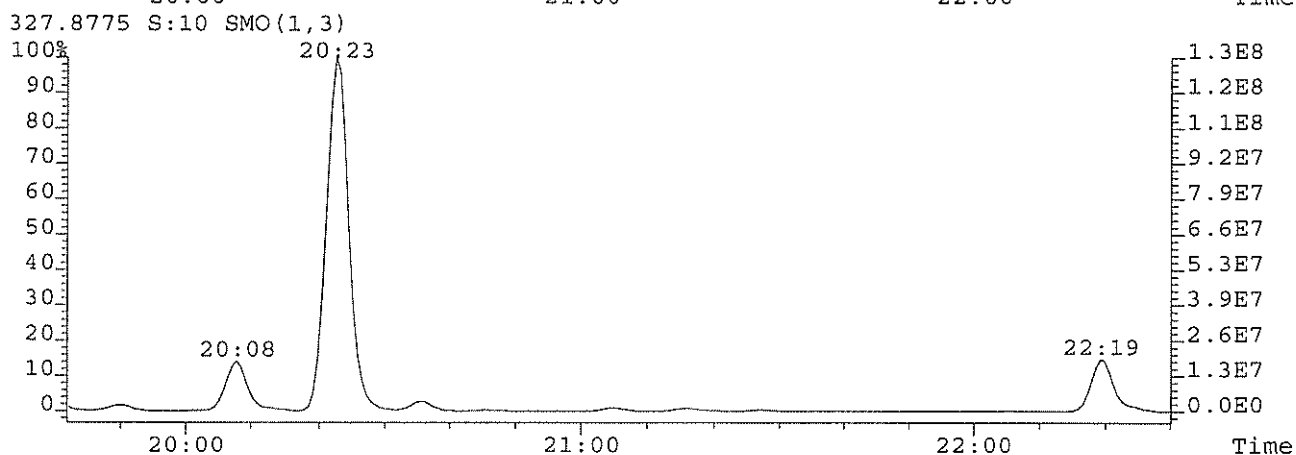
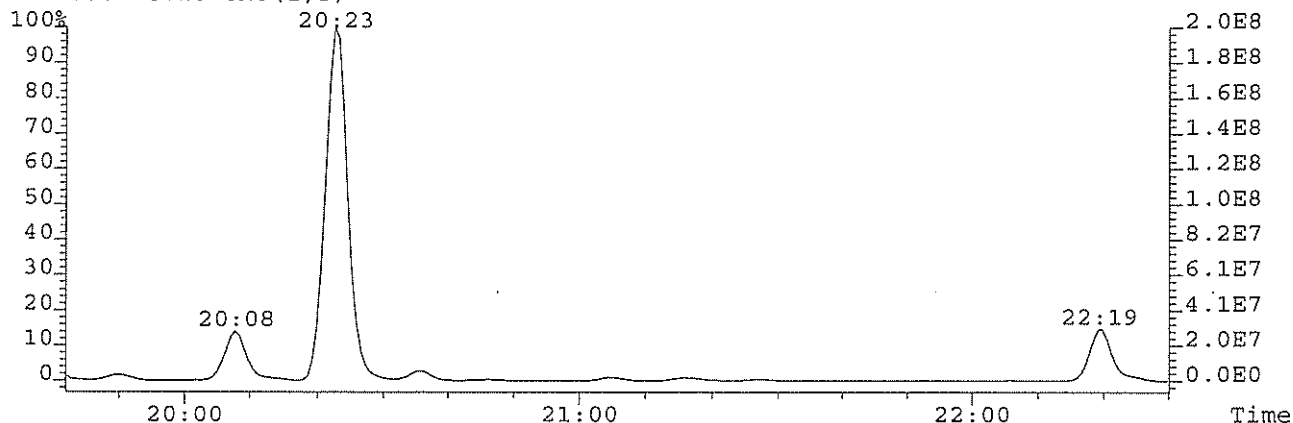
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 07:15:16 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0954 3 Exp:RH-PD22  
359.8415 S:16 SMO(1,3)



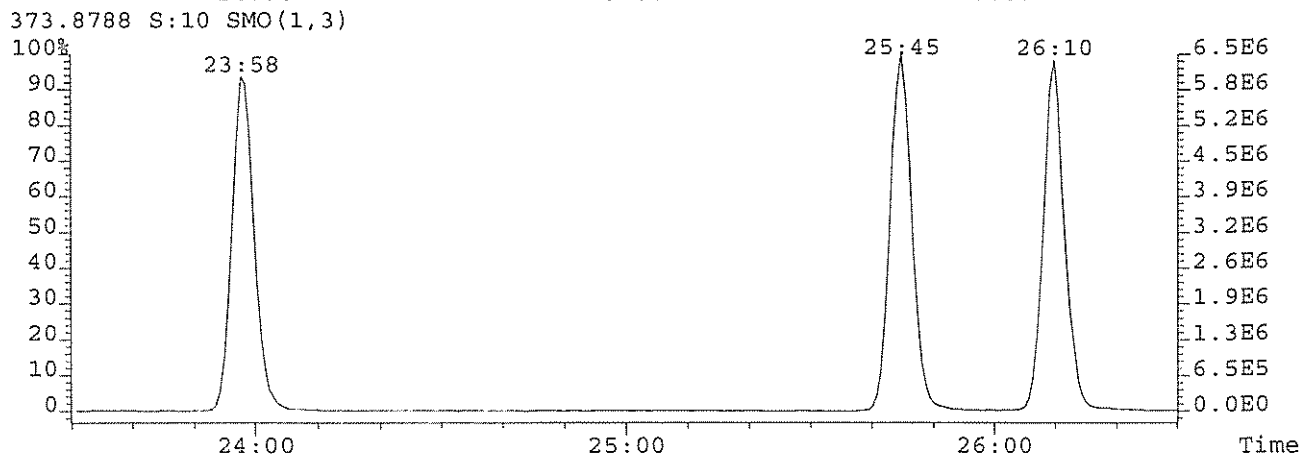
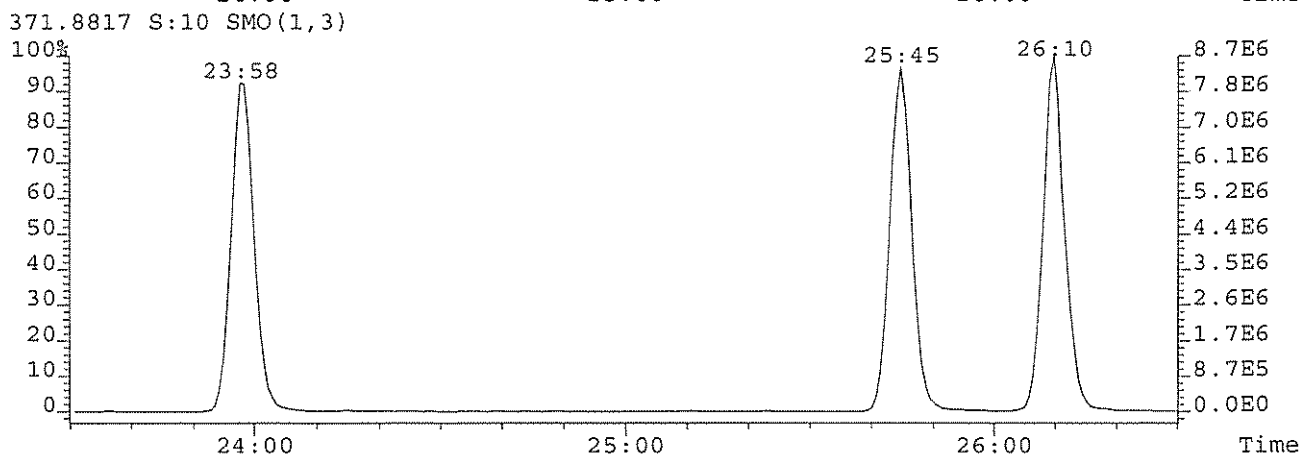
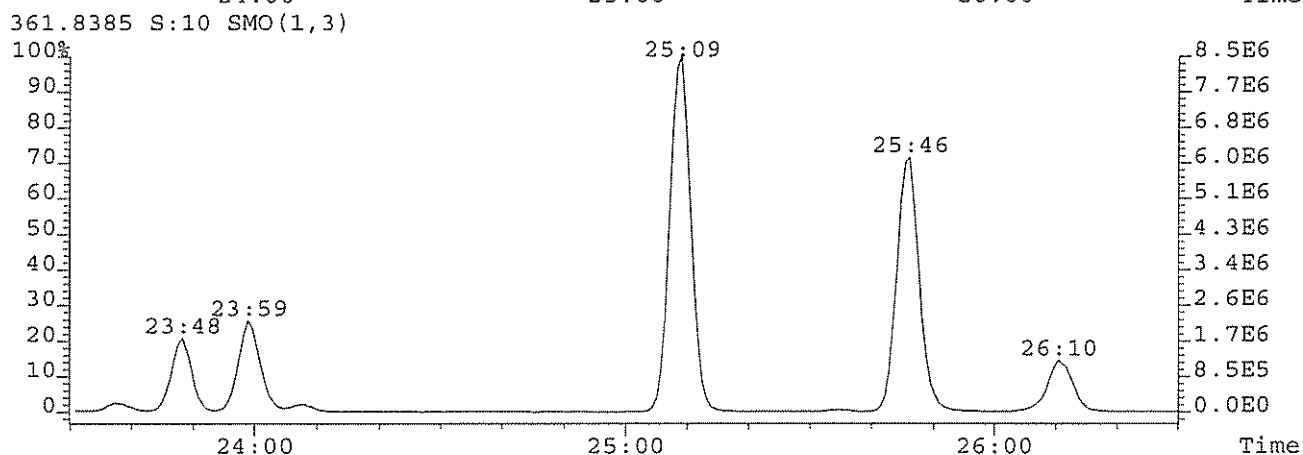
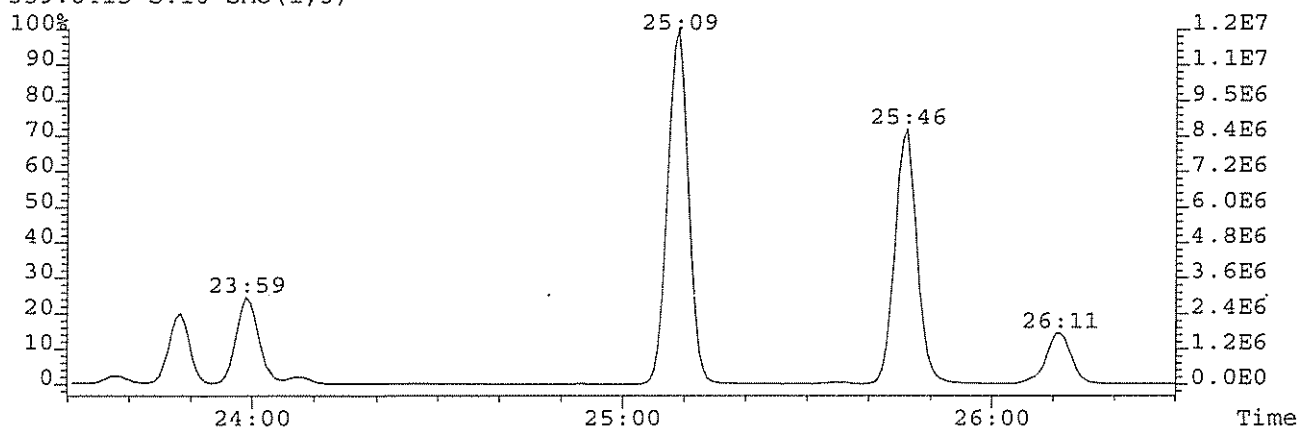
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130713 #1-2899 Acq:13-JUL-2013 18:08:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:RH-12ms(mP) Text:XE13 0954 2 1/100 Exp:RH-MP11  
325.8804 S:10 SMO(1,3)



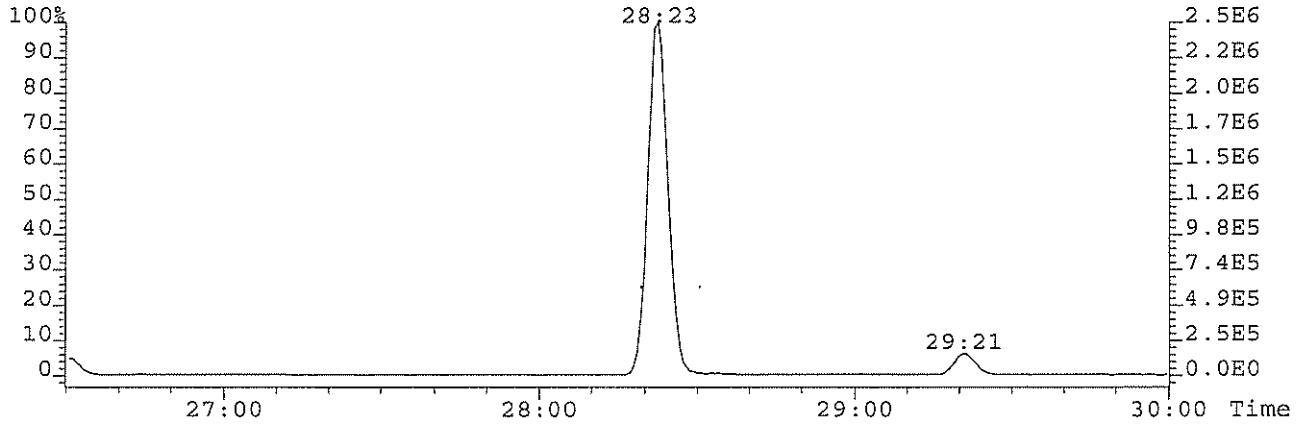
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130713 #1-2899 Acq:13-JUL-2013 18:08:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:RH-12ms(mP) Text:XE13 0954 2 1/100 Exp:RH-MP11  
359.8415 S:10 SMO(1,3)

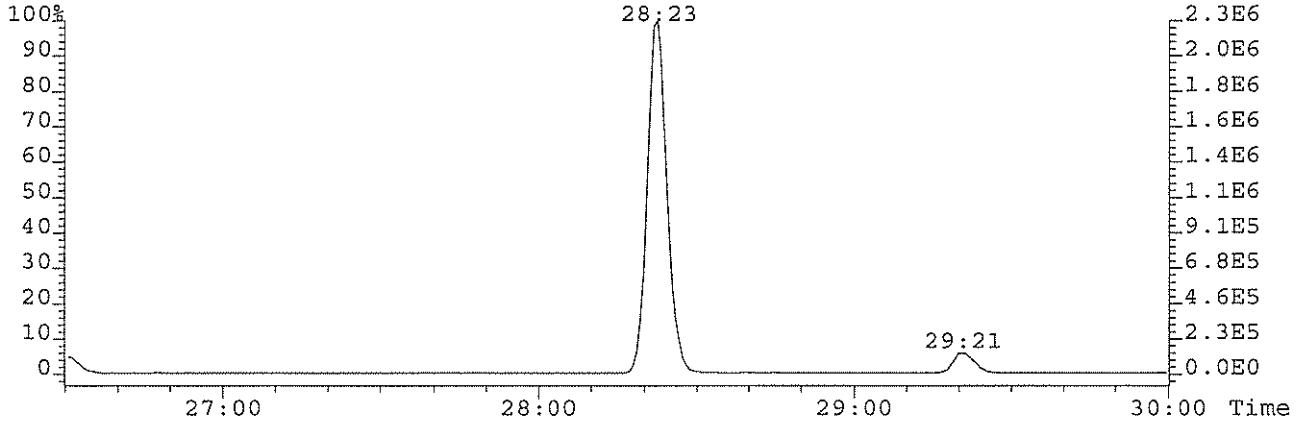


DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

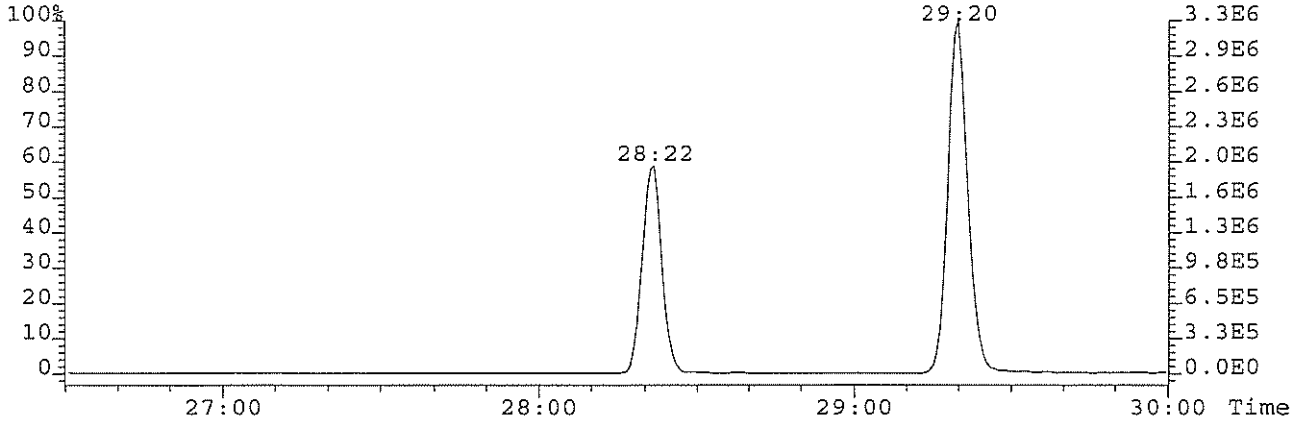
File:130713 #1-2899 Acq:13-JUL-2013 18:08:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#10 File Text:RH-12ms(mP) Text:XE13 0954 2 1/100 Exp:RH-MP11  
393.8025 S:10 SMO(1,3)



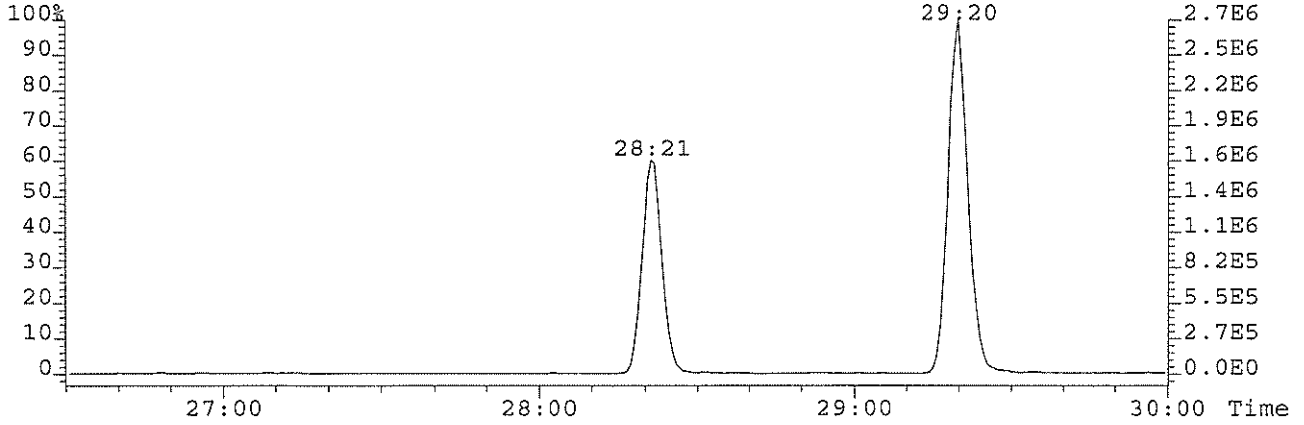
395.7995 S:10 SMO(1,3)



405.8428 S:10 SMO(1,3)



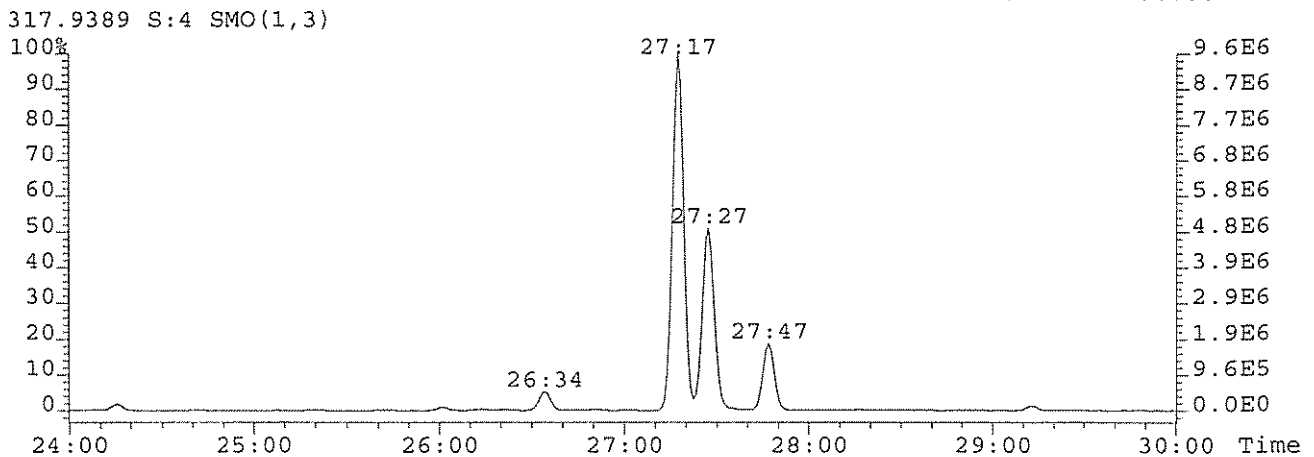
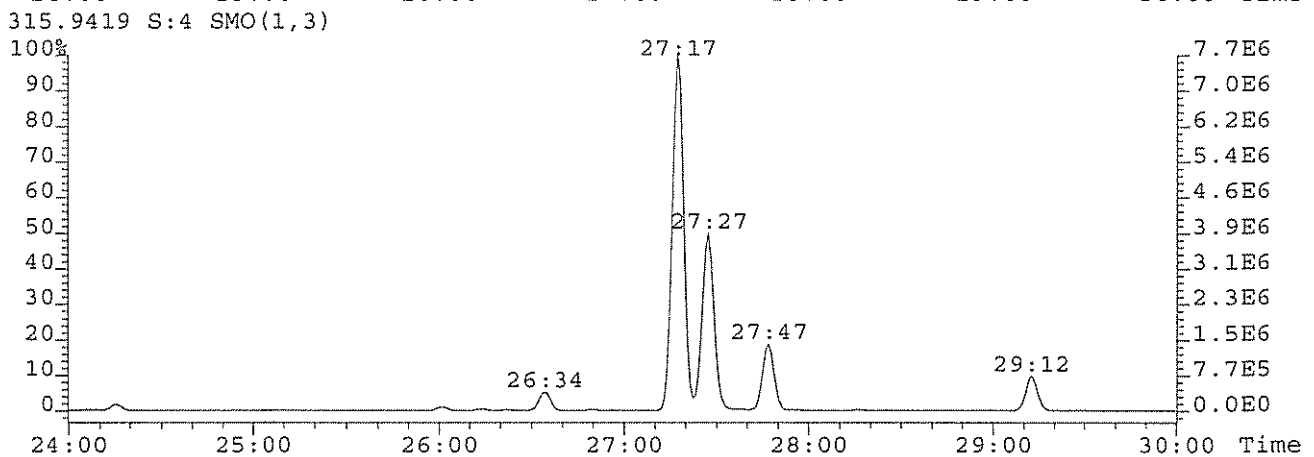
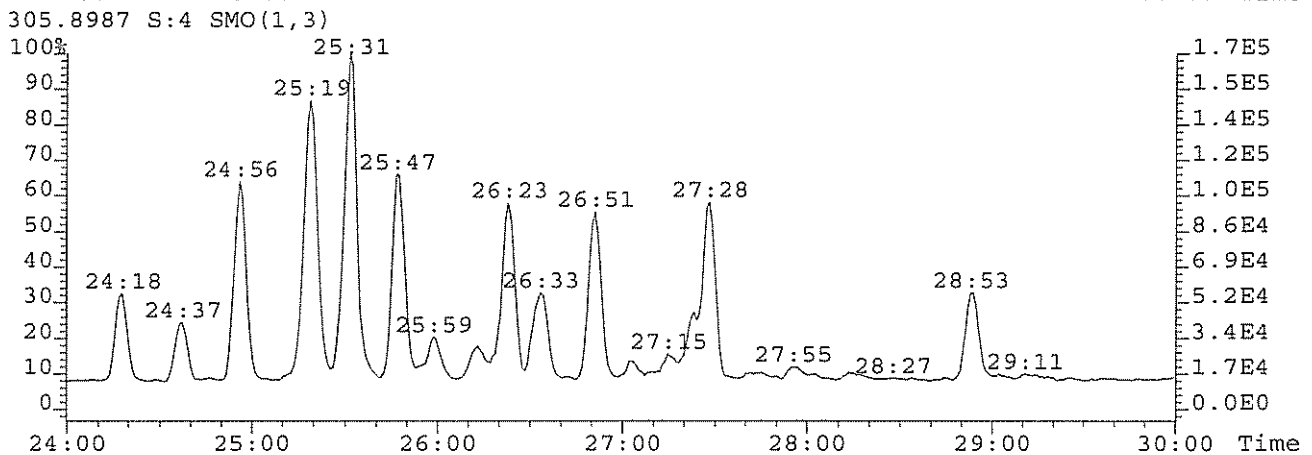
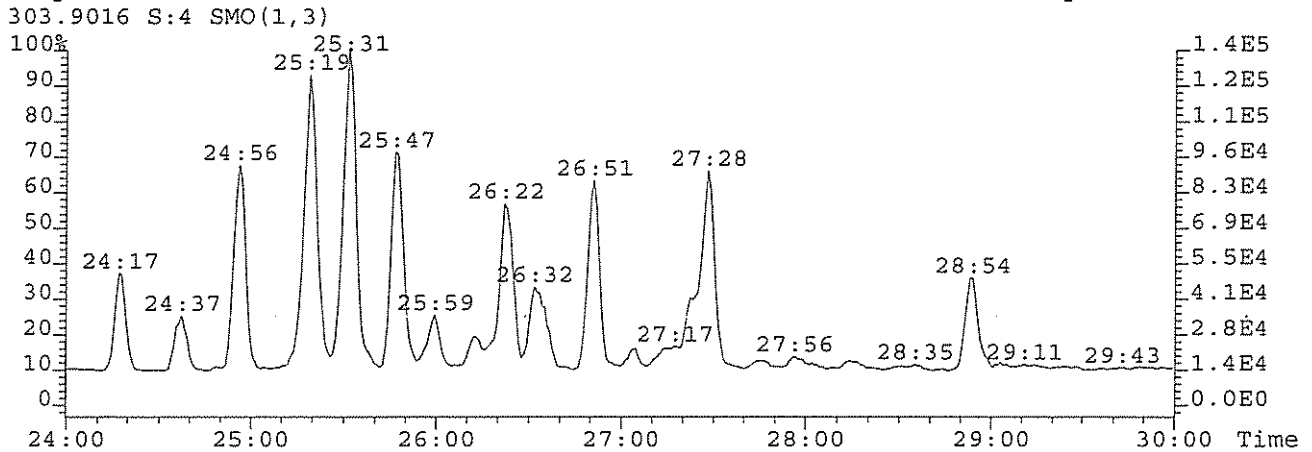
407.8398 S:10 SMO(1,3)



DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

試料管理番号	XE 130955
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.9

File:130716 #1-2009 Acq:16-JUL-2013 14:47:43 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:BPX-DXN(4-6DXN) Text:XE13 0955 Exp:BPX03

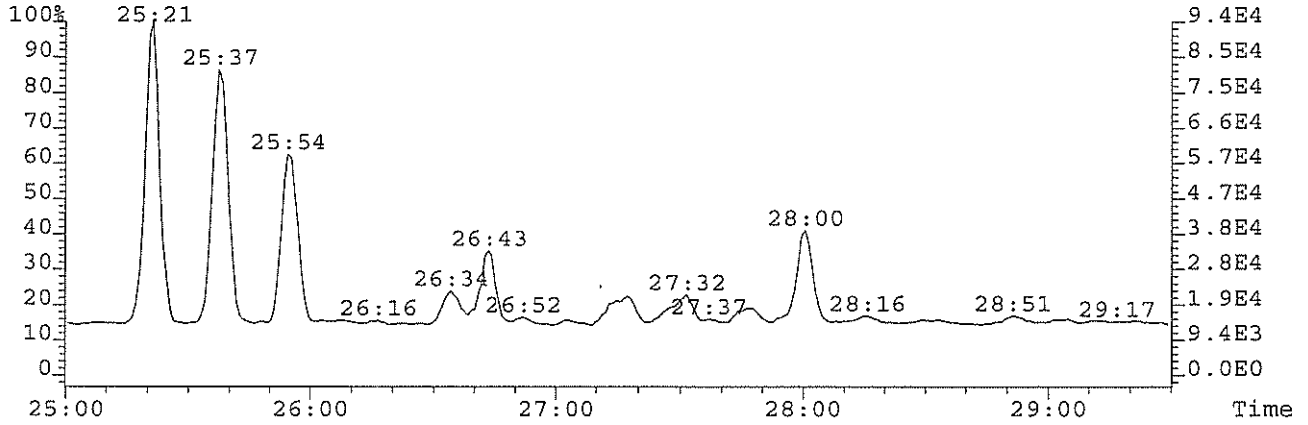


PCDFsクロマトグラム (1)  
(TeCDFs)

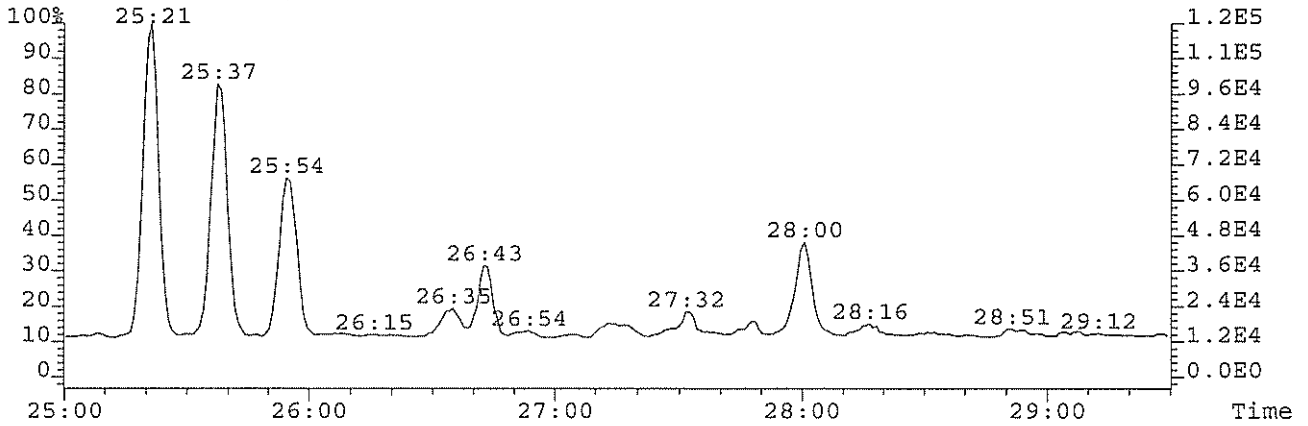


File:130716 #1-2009 Acq:16-JUL-2013 14:47:43 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:BPX-DXN(4-6DXN) Text:XE13 0955 Exp:BPX03

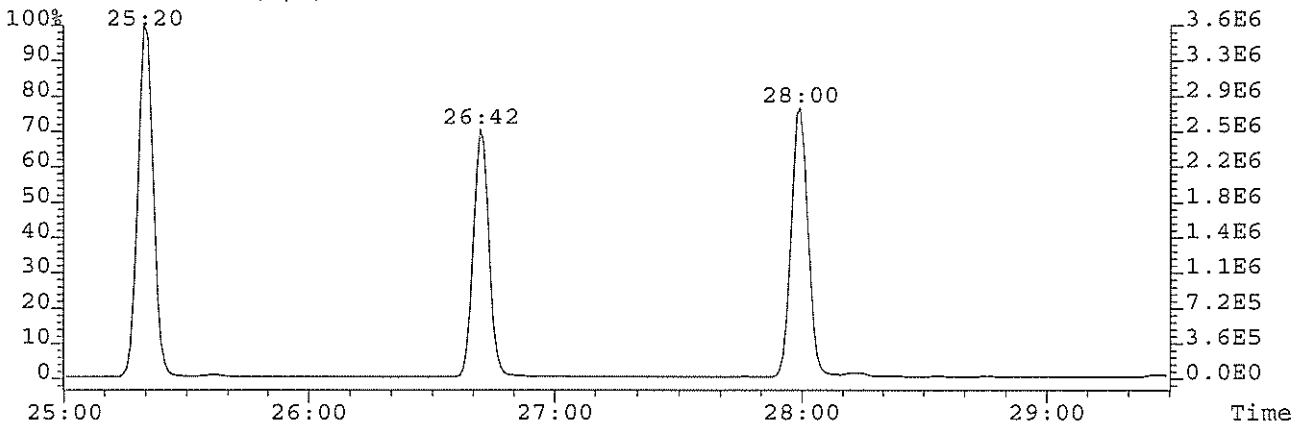
319.8965 S:4 SMO(1,3)



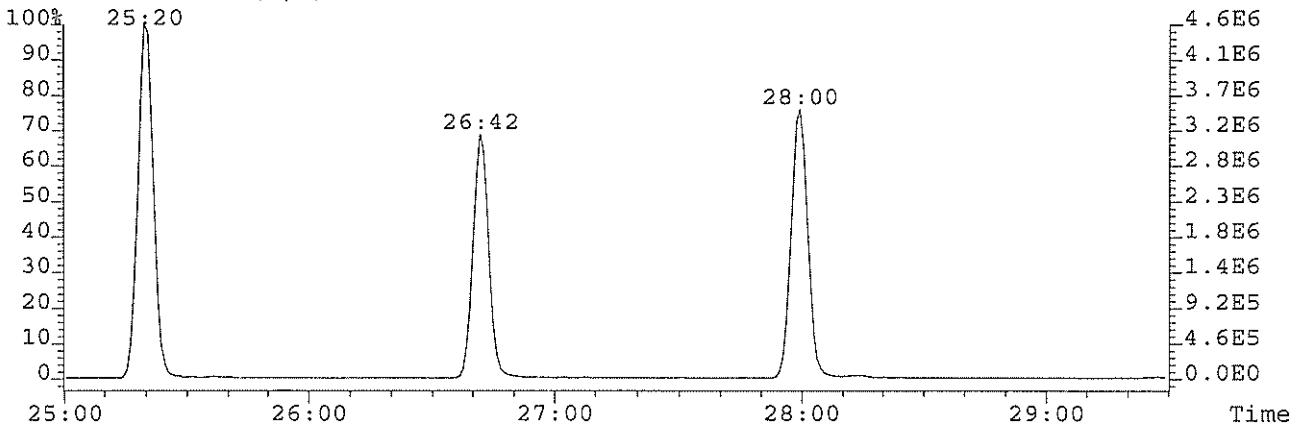
321.8936 S:4 SMO(1,3)



331.9368 S:4 SMO(1,3)

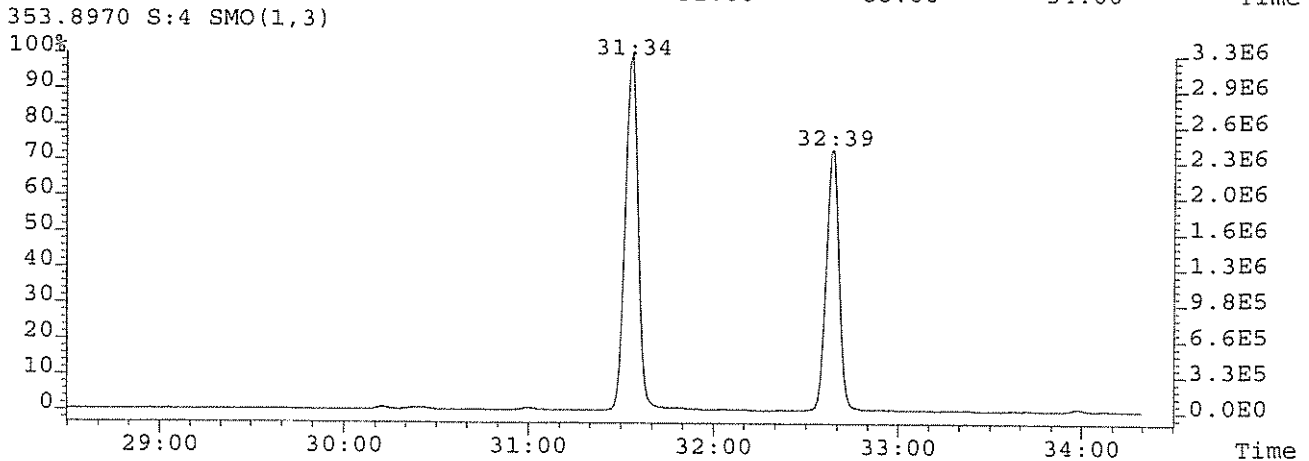
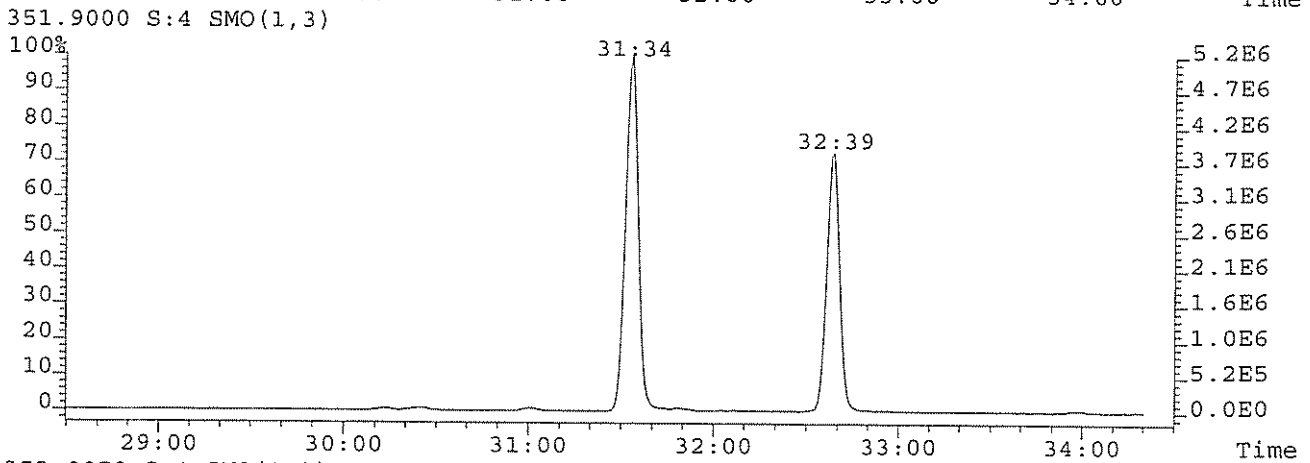
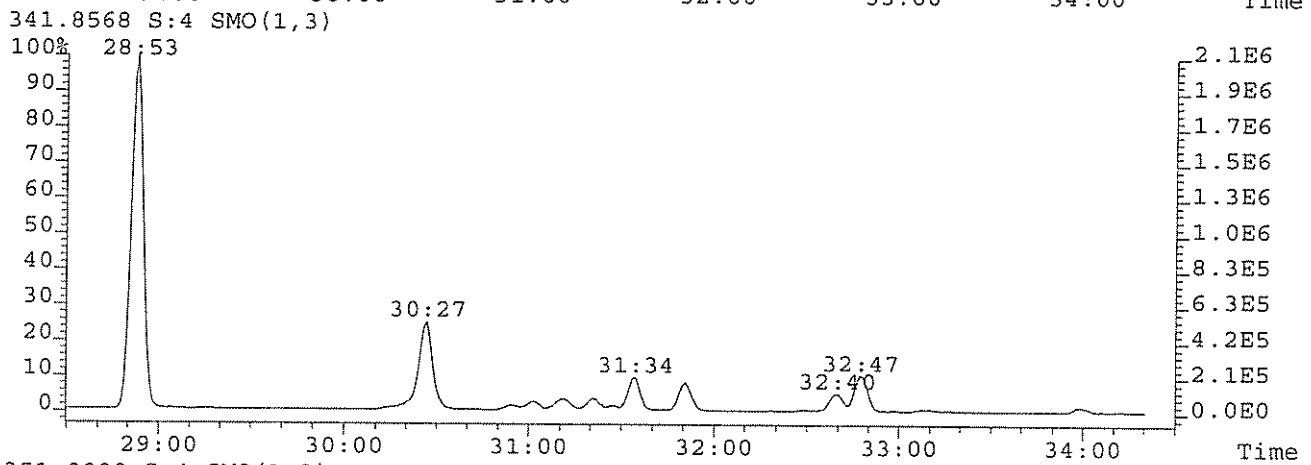
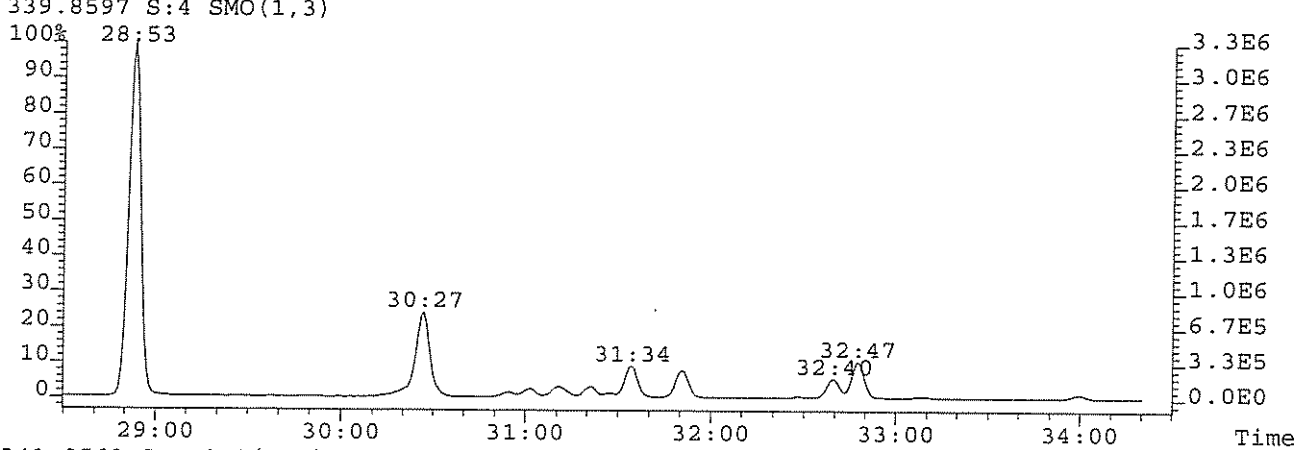


333.9339 S:4 SMO(1,3)



PCDDsクロマトグラム (2)  
(TeCDDs)

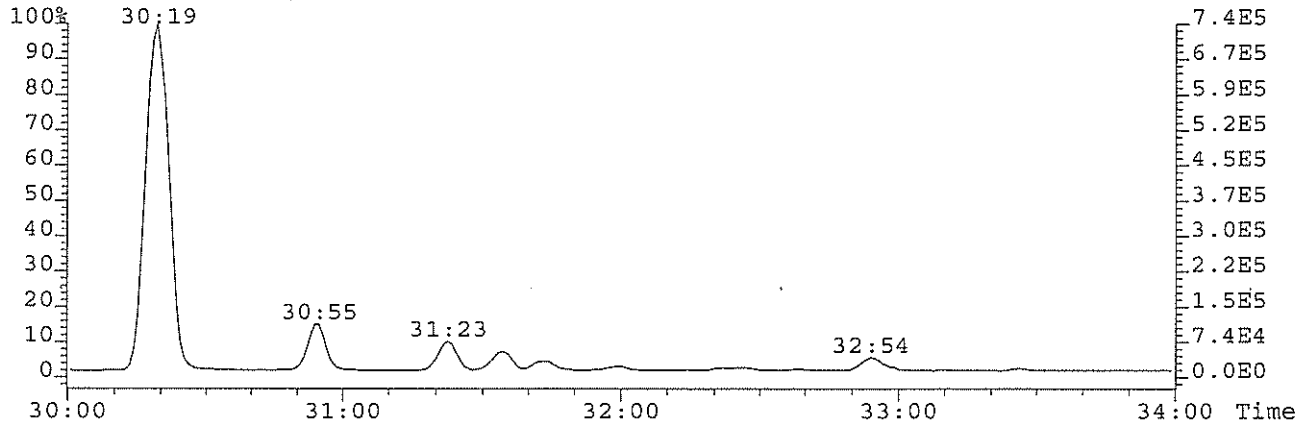
File:130716 #1-2009 Acq:16-JUL-2013 14:47:43 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:BPX-DXN(4-6DXN) Text:XE13 0955 Exp:BPX03



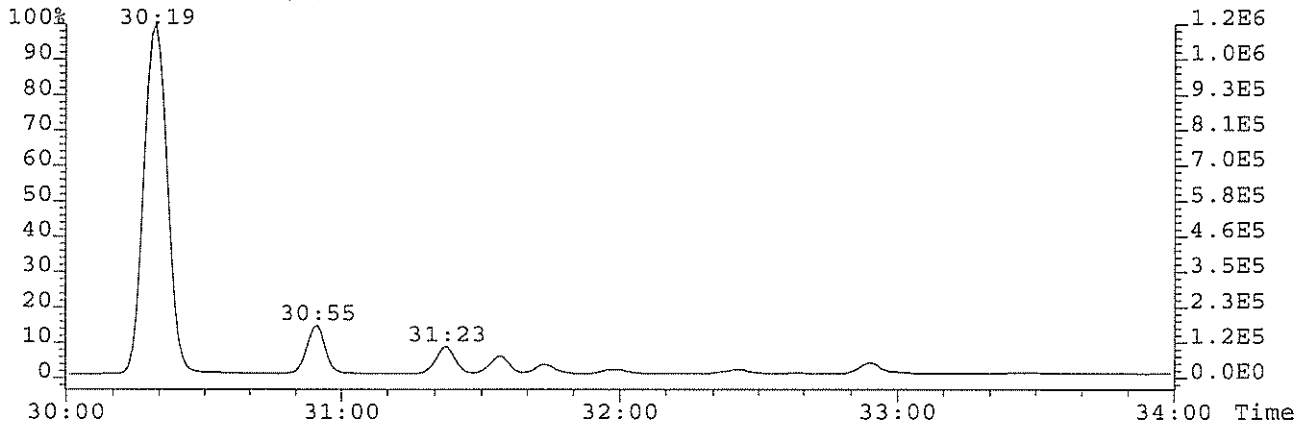
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130716 #1-2009 Acq:16-JUL-2013 14:47:43 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:BPX-DXN(4-6DXN) Text:XE13 0955 Exp:BPX03

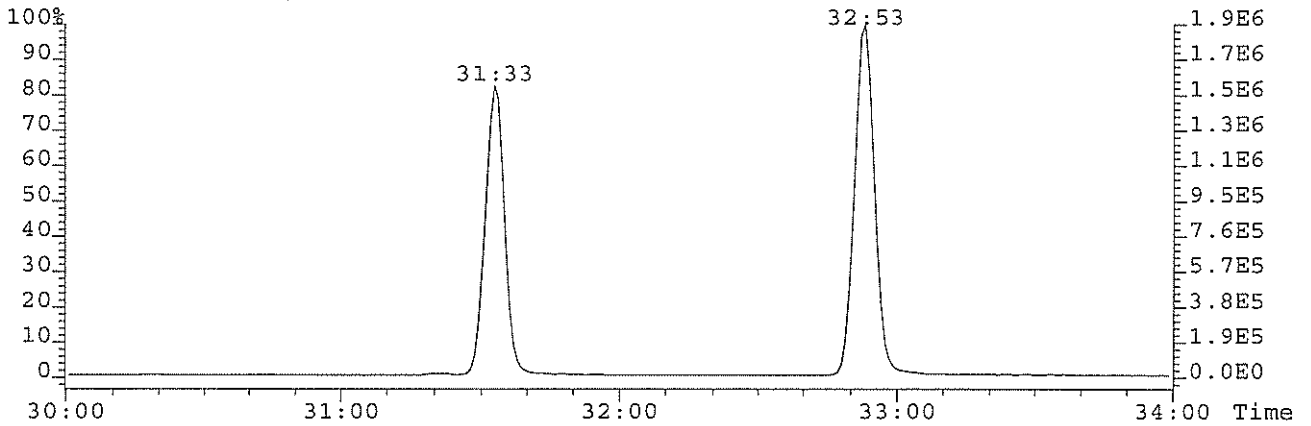
353.8576 S:4 SMO(1,3)



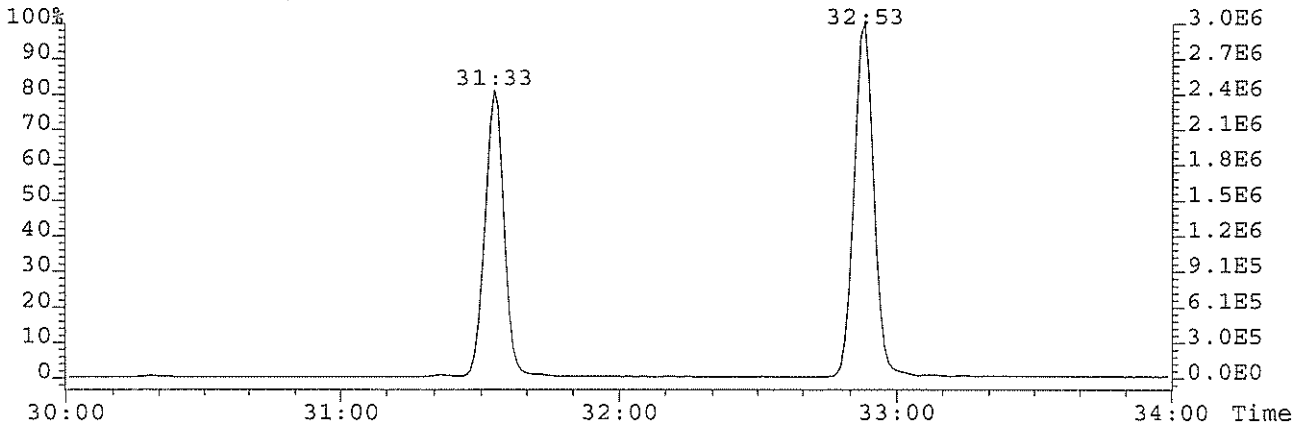
355.8546 S:4 SMO(1,3)



365.8978 S:4 SMO(1,3)



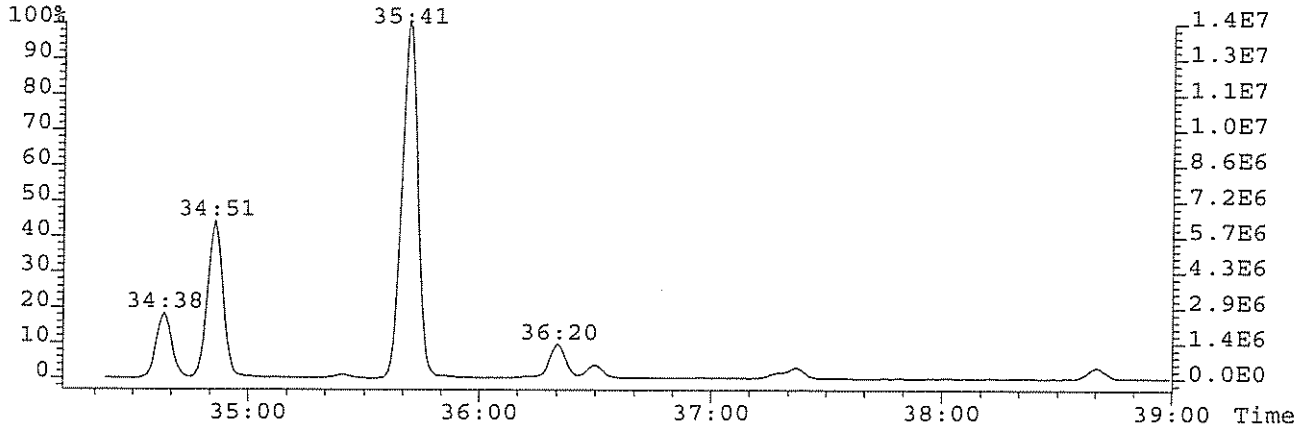
367.8949 S:4 SMO(1,3)



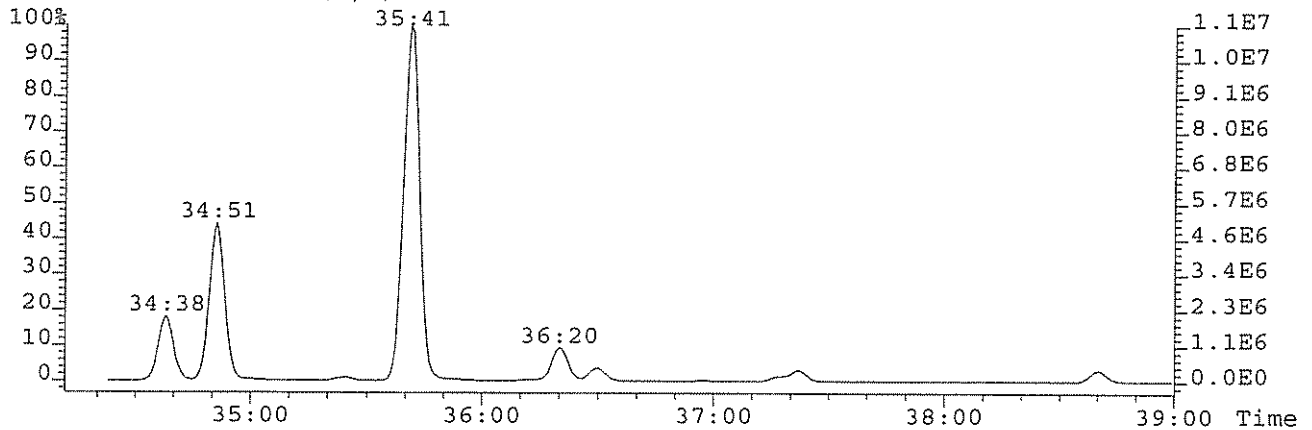
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130716 #1-1955 Acq:16-JUL-2013 14:47:43 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:BPX-DXN(4-6DXN) Text:XE13 0955 Exp:BPX03

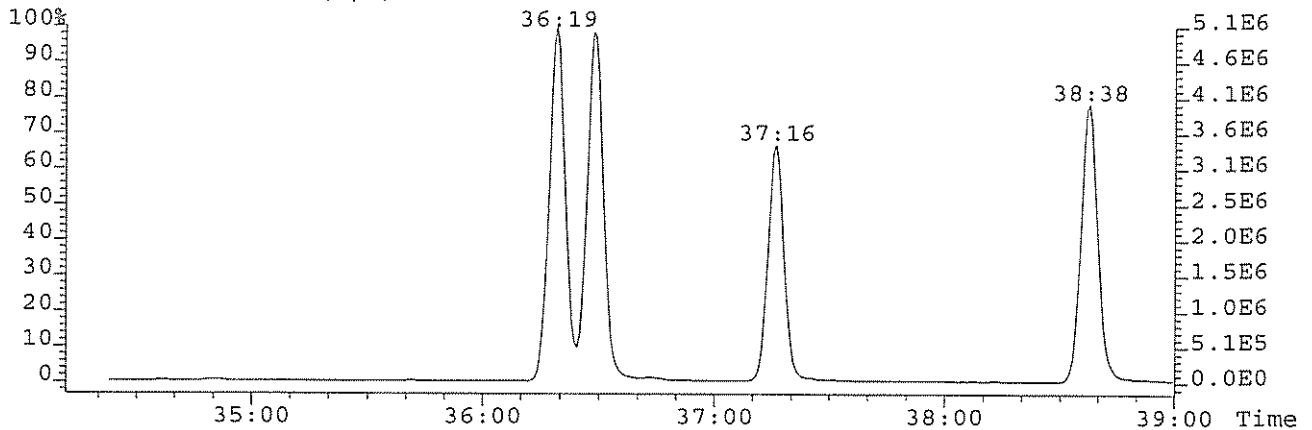
373.8207 S:4 F:2 SMO(1,3)



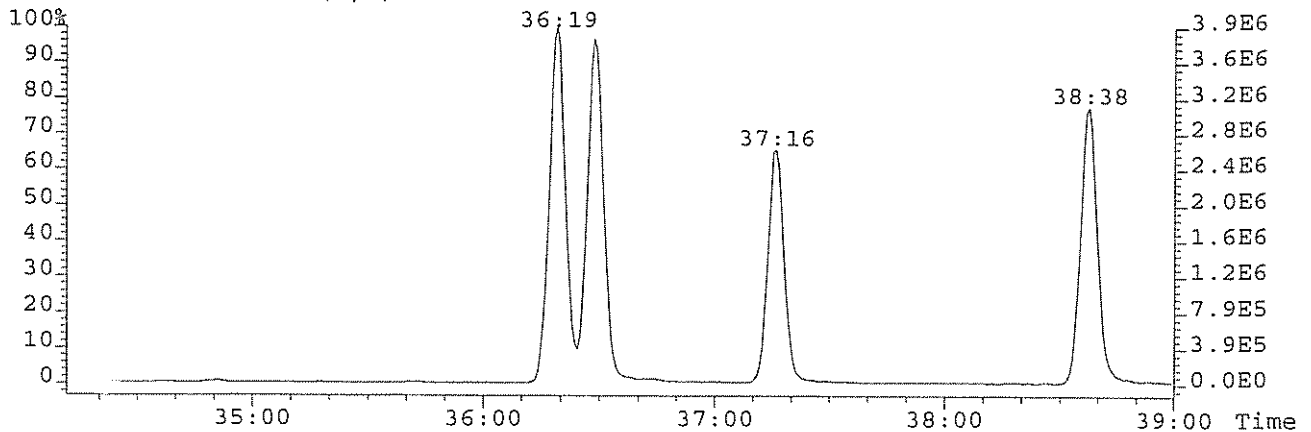
375.8178 S:4 F:2 SMO(1,3)



385.8610 S:4 F:2 SMO(1,3)

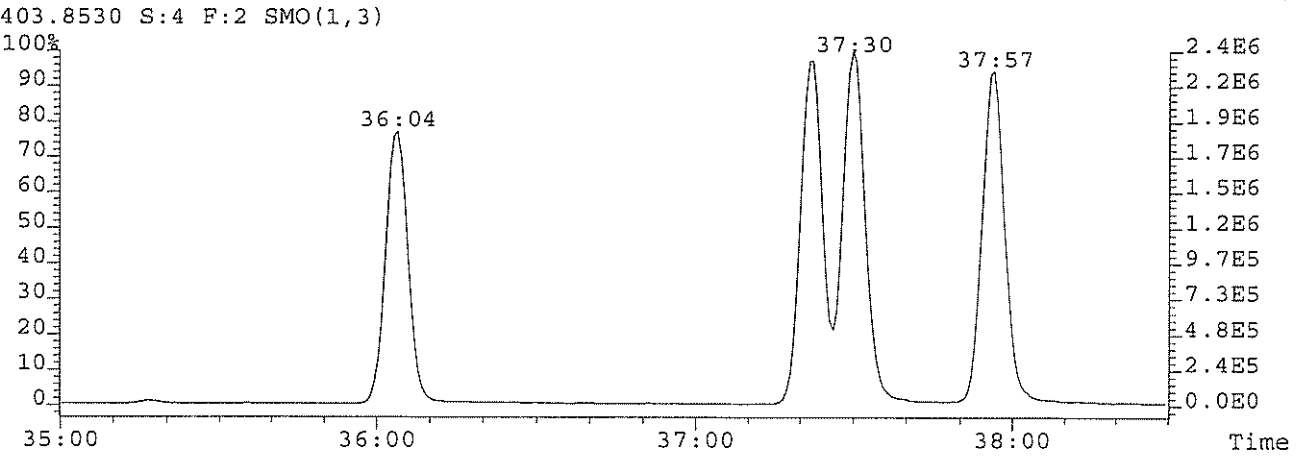
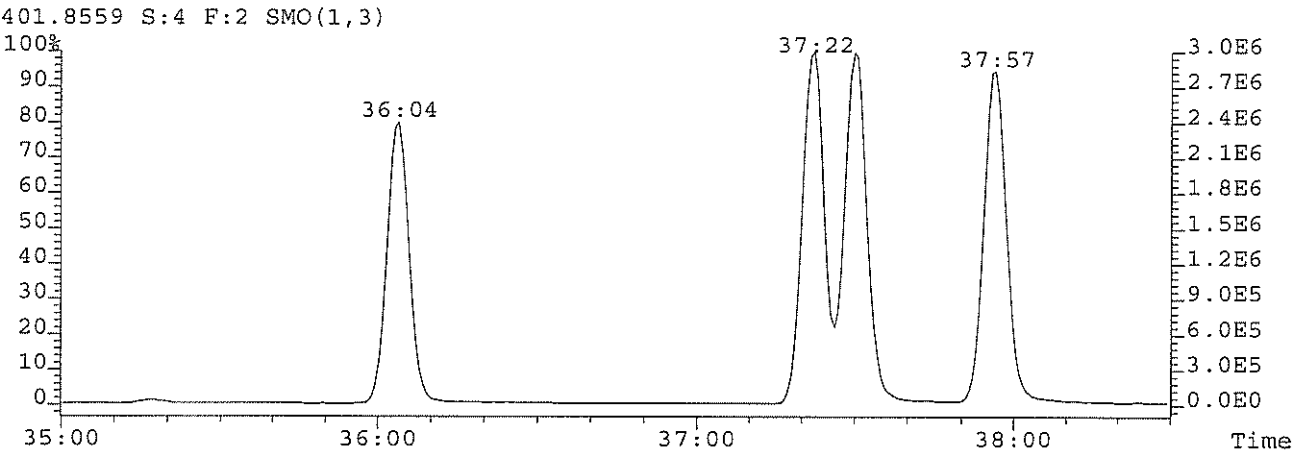
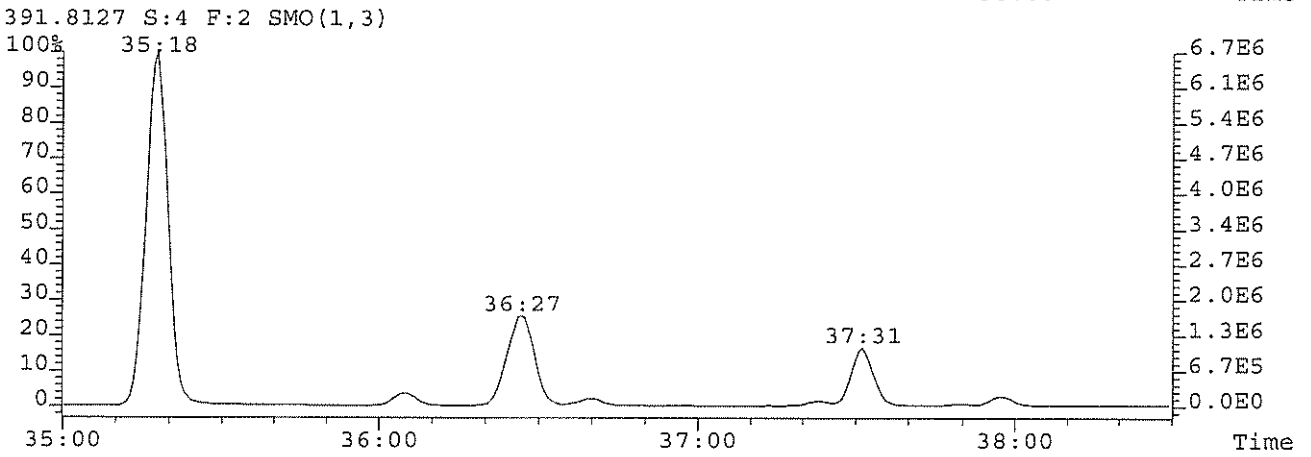
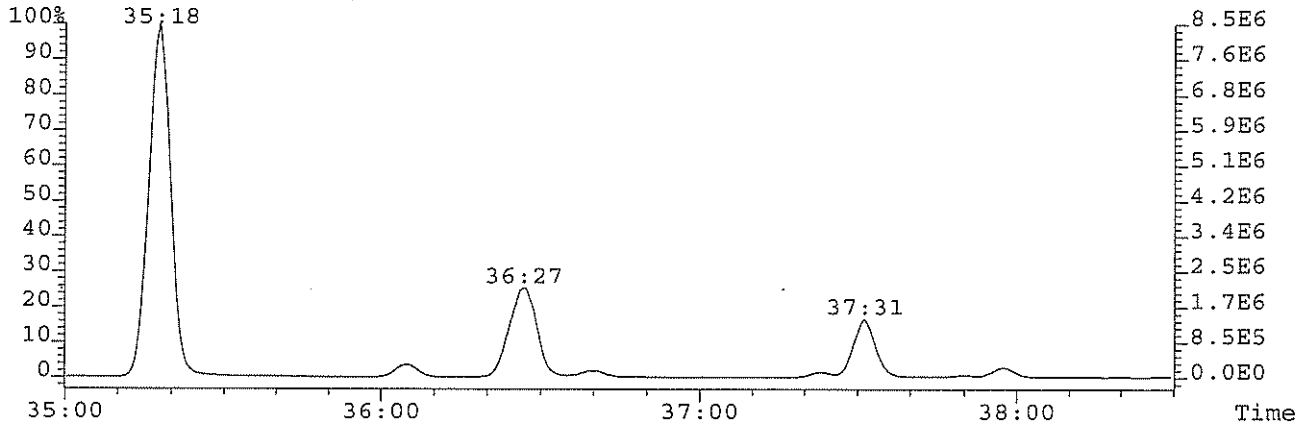


387.8580 S:4 F:2 SMO(1,3)



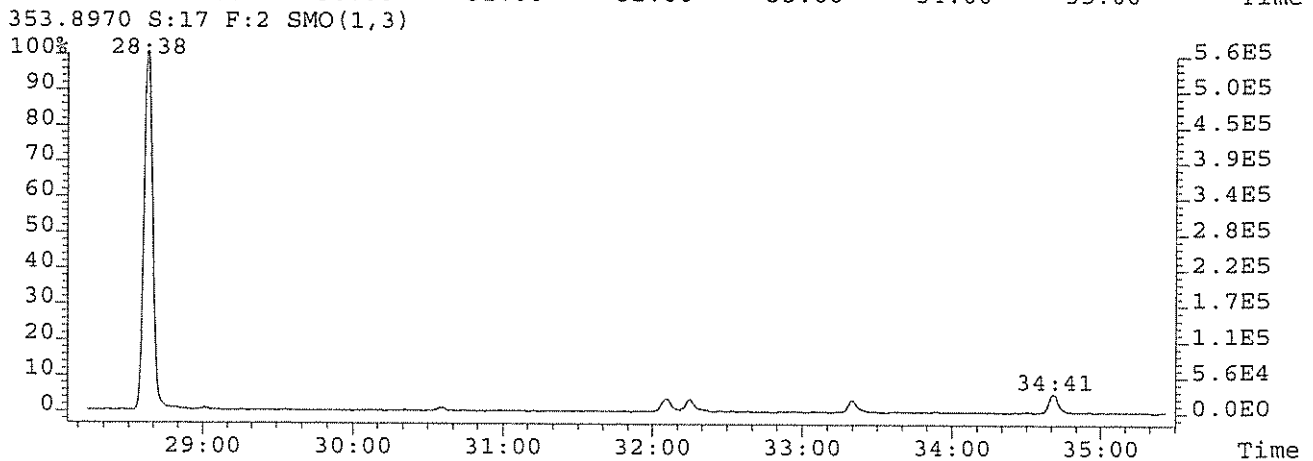
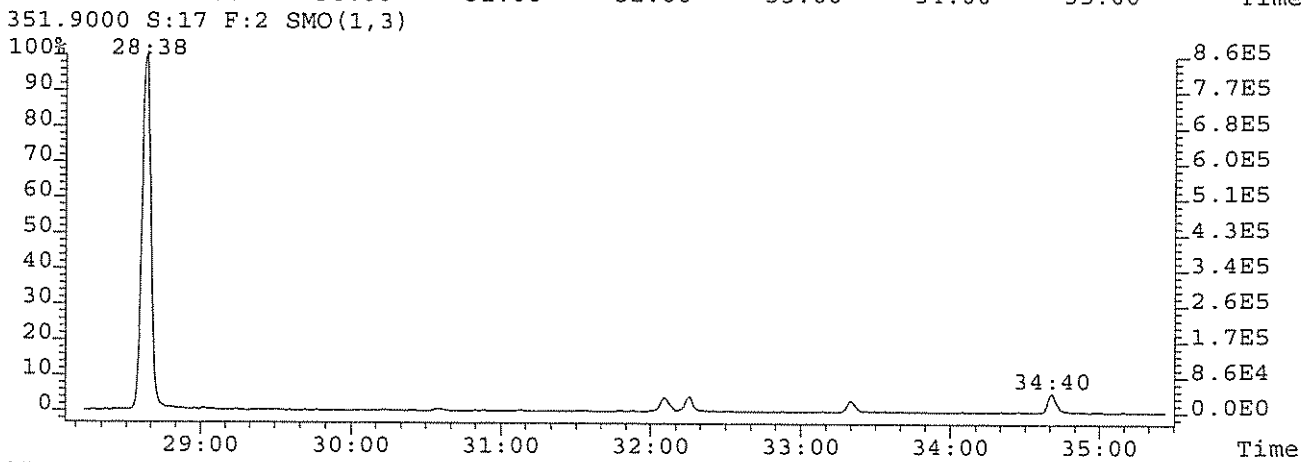
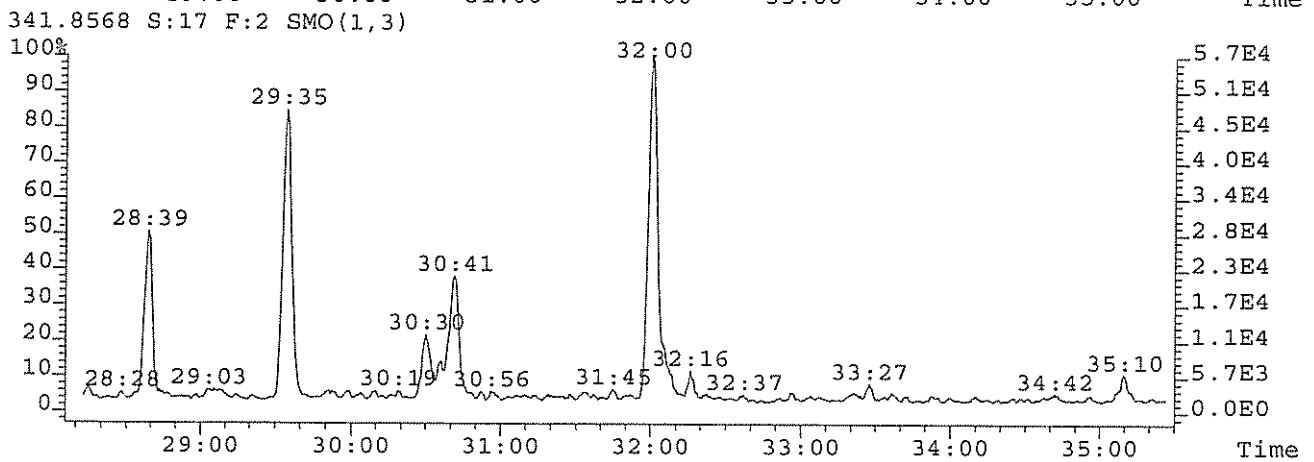
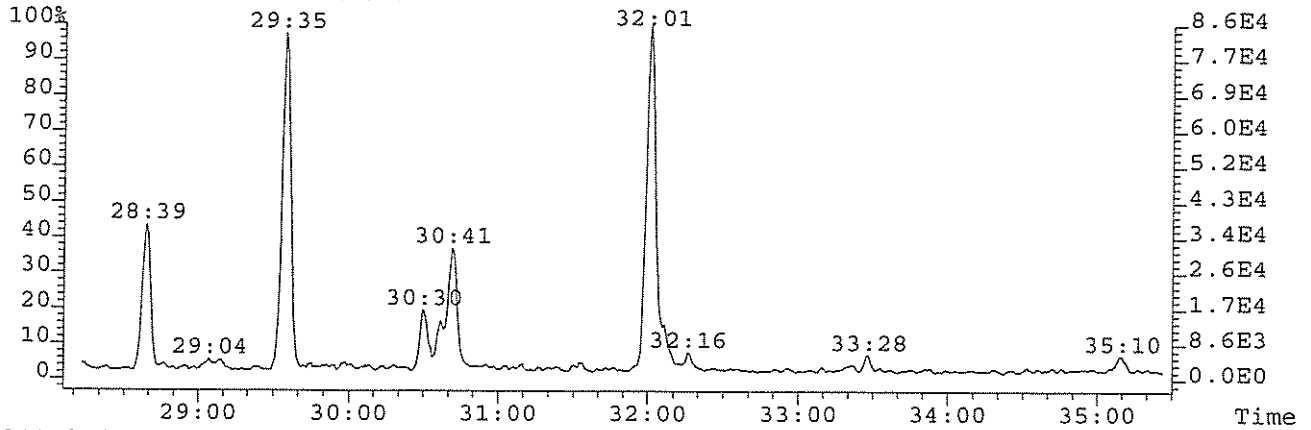
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130716 #1-1955 Acq:16-JUL-2013 14:47:43 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:BPX-DXN(4-6DXN) Text:XE13 0955 Exp:BPX03  
389.8156 S:4 F:2 SMO(1,3)



PCDDsクロマトグラム (6)  
(HxCDDs)

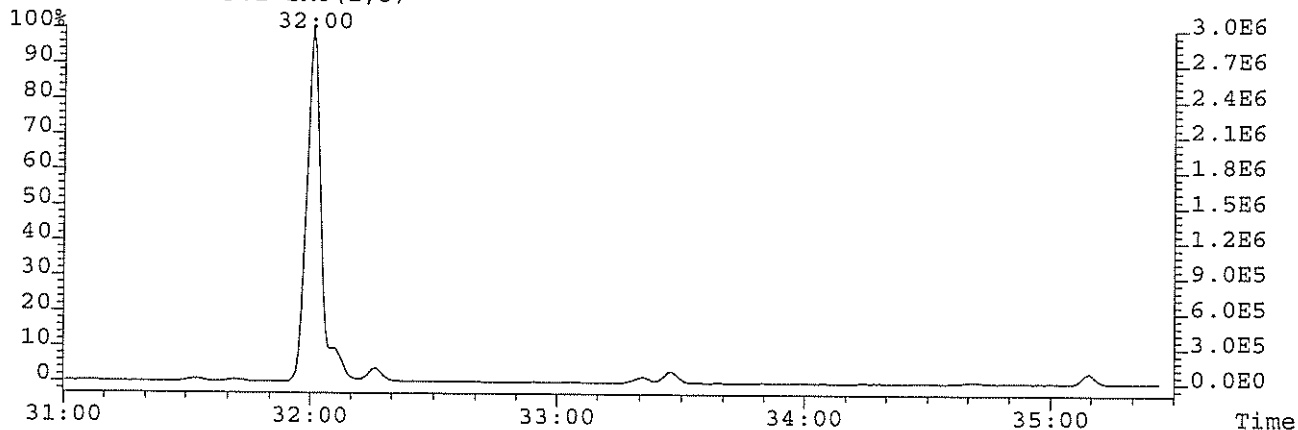
File:130711-2 #1-649 Acq:12-JUL-2013 08:04:39 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0955 3 Exp:RH-PD22  
339.8597 S:17 F:2 SMO(1,3)



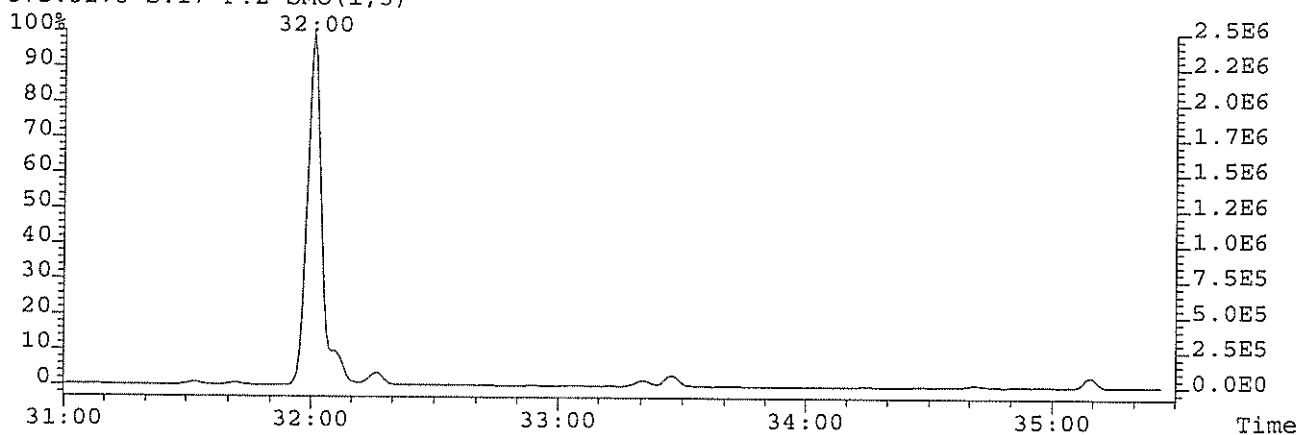
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130711-2 #1-649 Acq:12-JUL-2013 08:04:39 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0955 3 Exp:RH-PD22

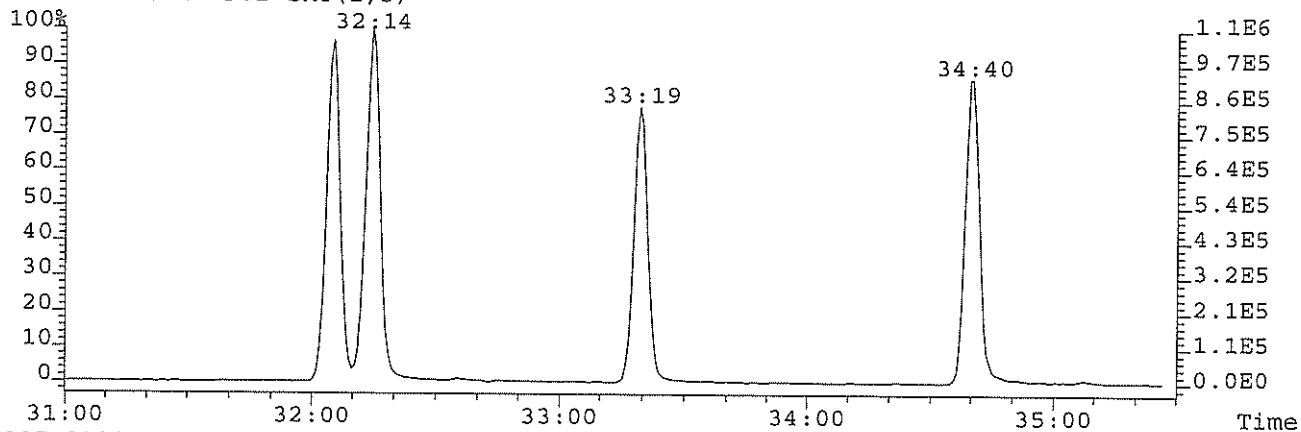
373.8207 S:17 F:2 SMO(1,3)



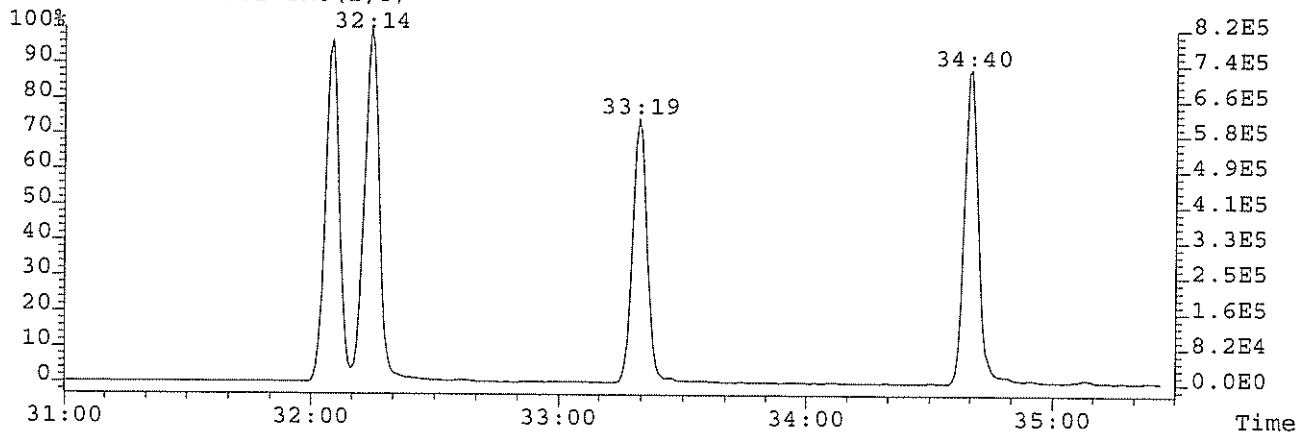
375.8178 S:17 F:2 SMO(1,3)



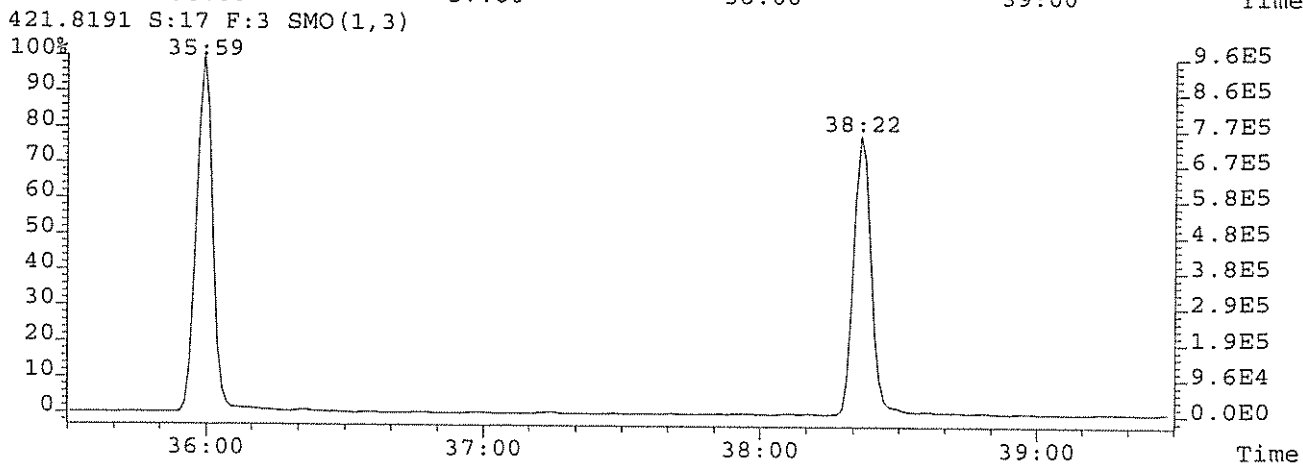
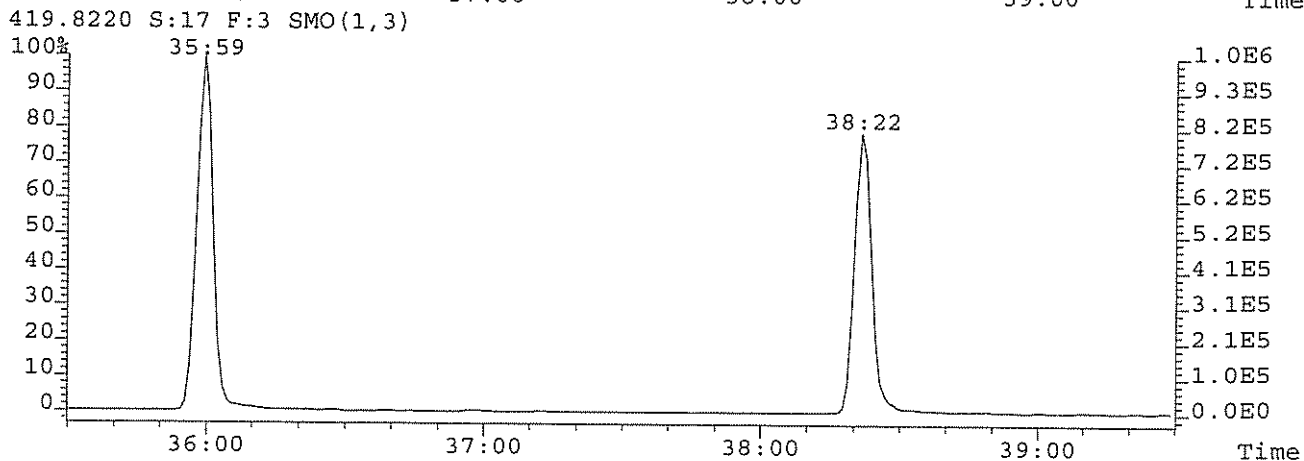
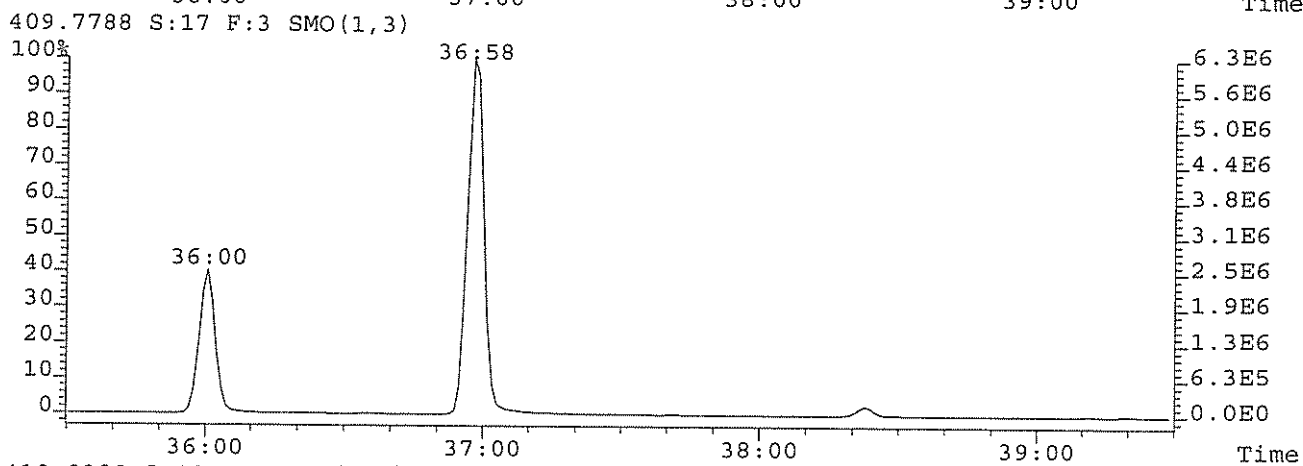
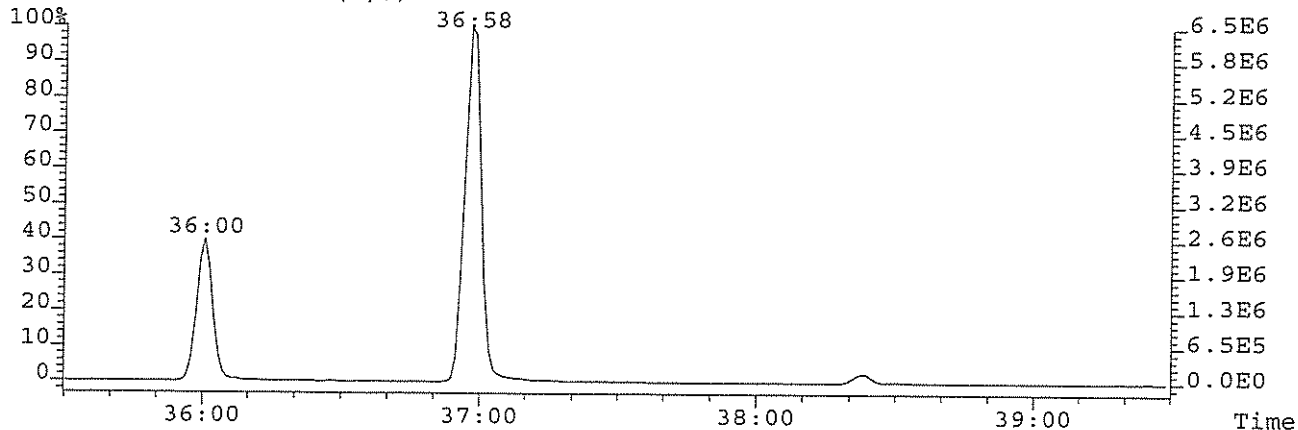
385.8610 S:17 F:2 SMO(1,3)



387.8580 S:17 F:2 SMO(1,3)



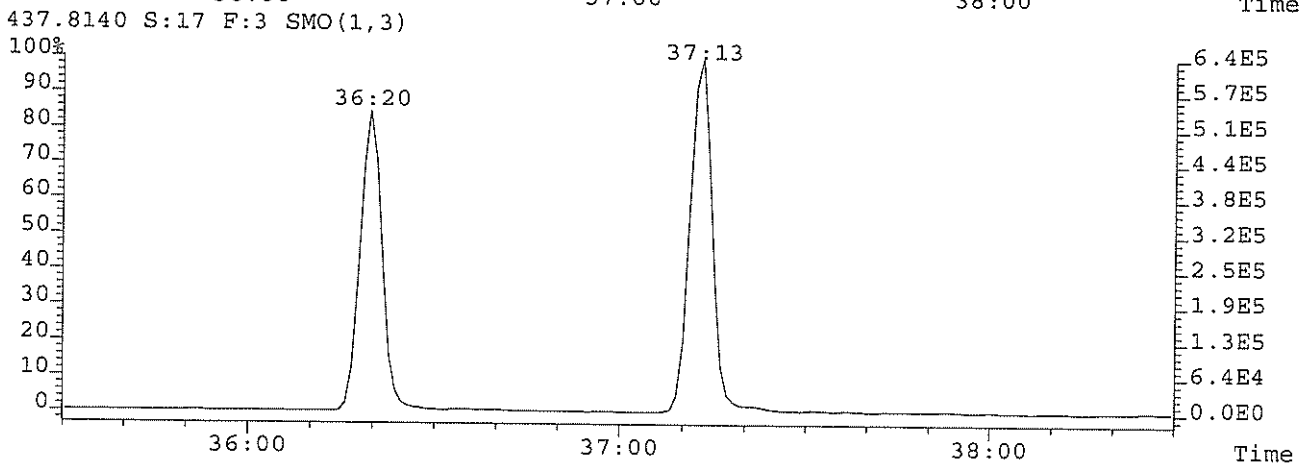
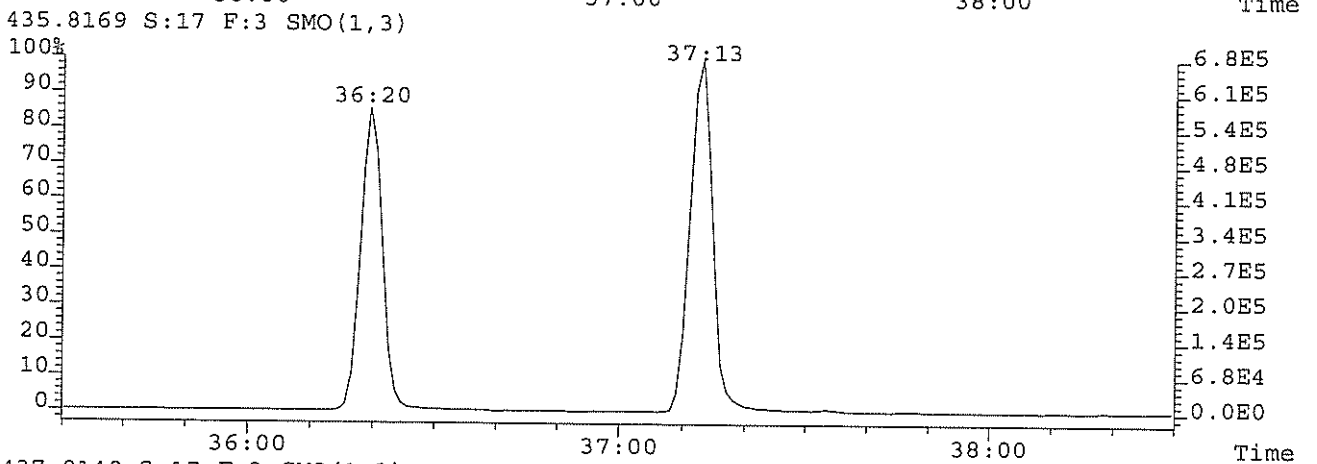
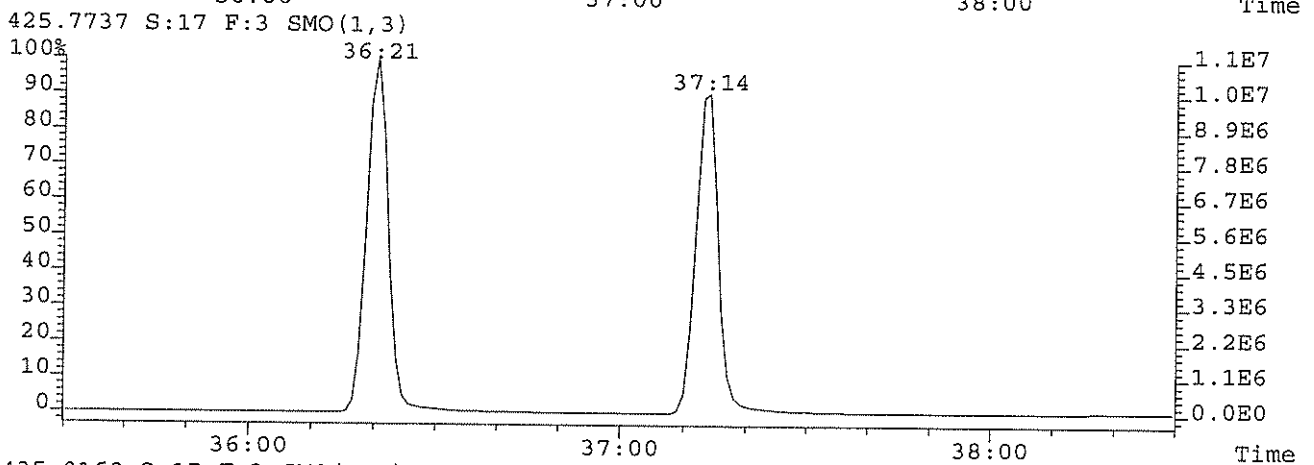
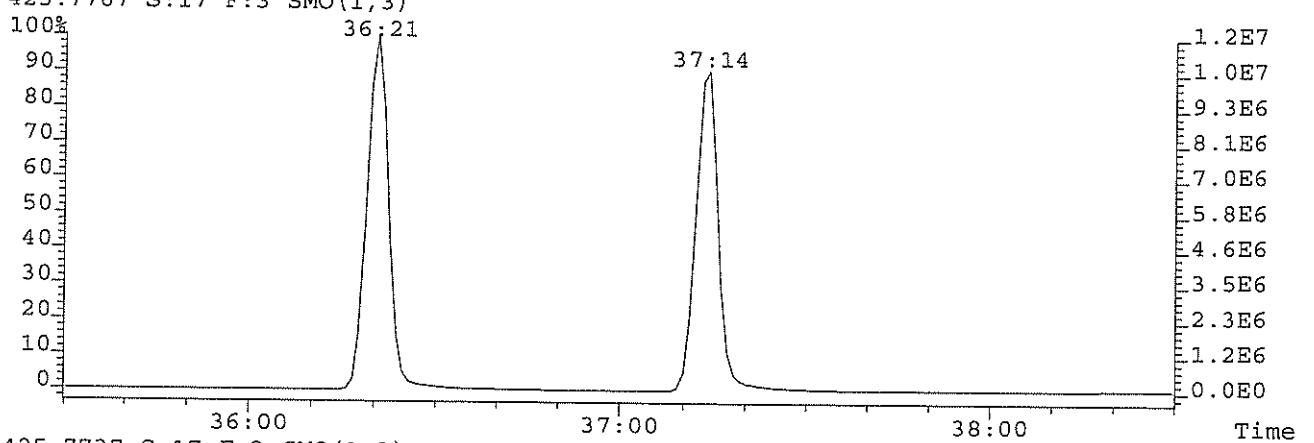
File:130711-2 #1-562 Acq:12-JUL-2013 08:04:39 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0955 3 Exp:RH-PD22



PCDFsクロマトグラム (9)  
(HpCDFs)



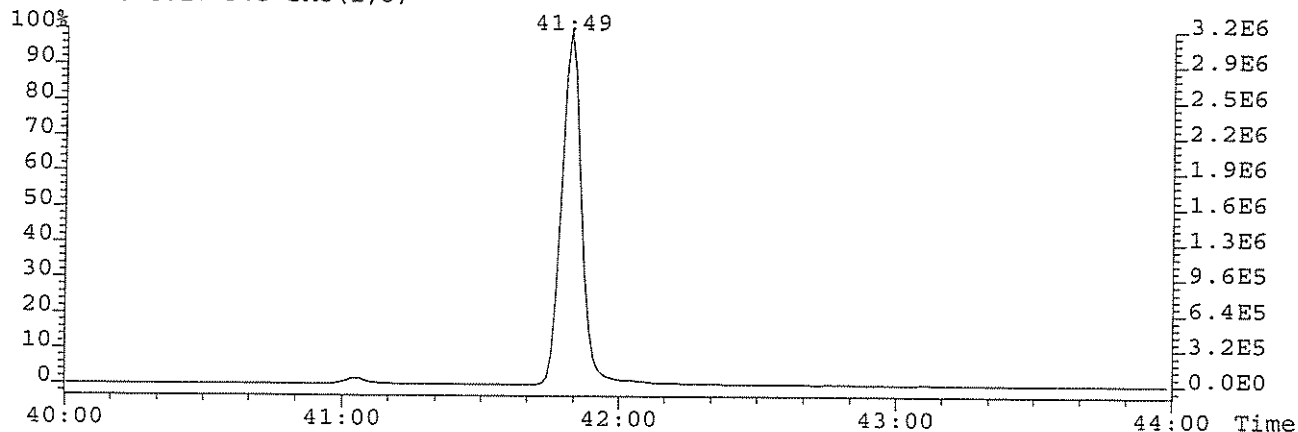
File:130711-2 #1-562 Acq:12-JUL-2013 08:04:39 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0955 3 Exp:RH-PD22



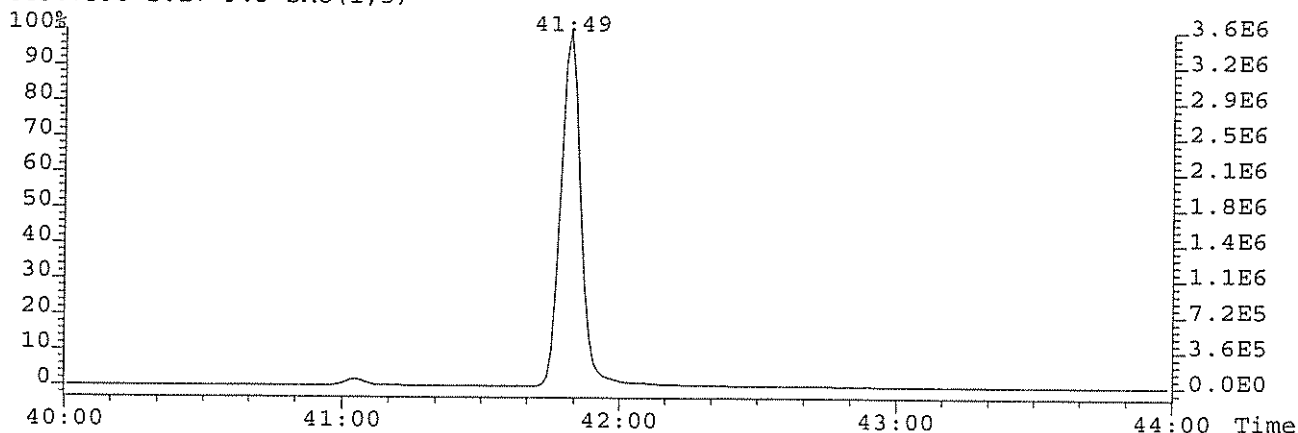
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130711-2 #1-562 Acq:12-JUL-2013 08:04:39 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0955 3 Exp:RH-PD22

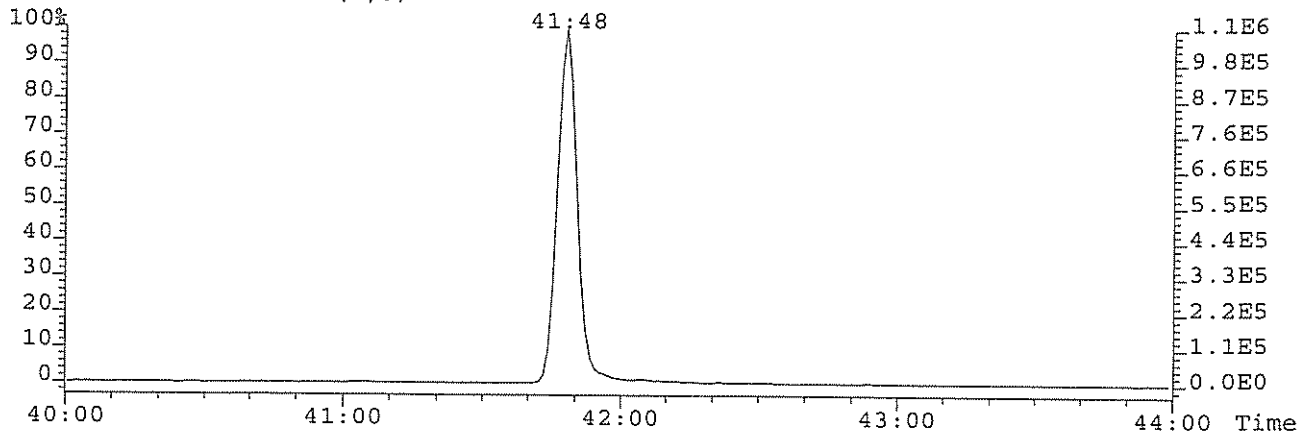
441.7428 S:17 F:3 SMO(1,3)



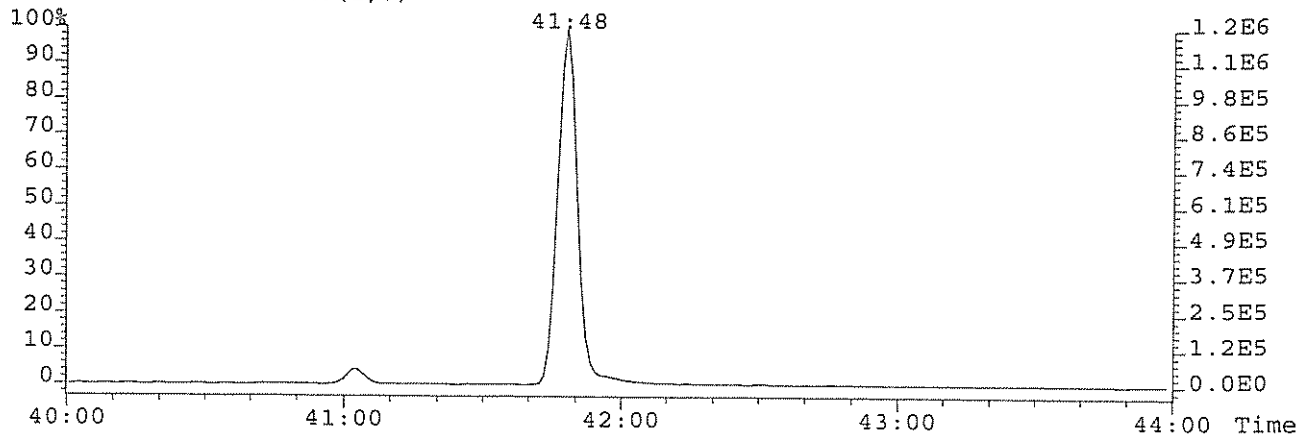
443.7398 S:17 F:3 SMO(1,3)



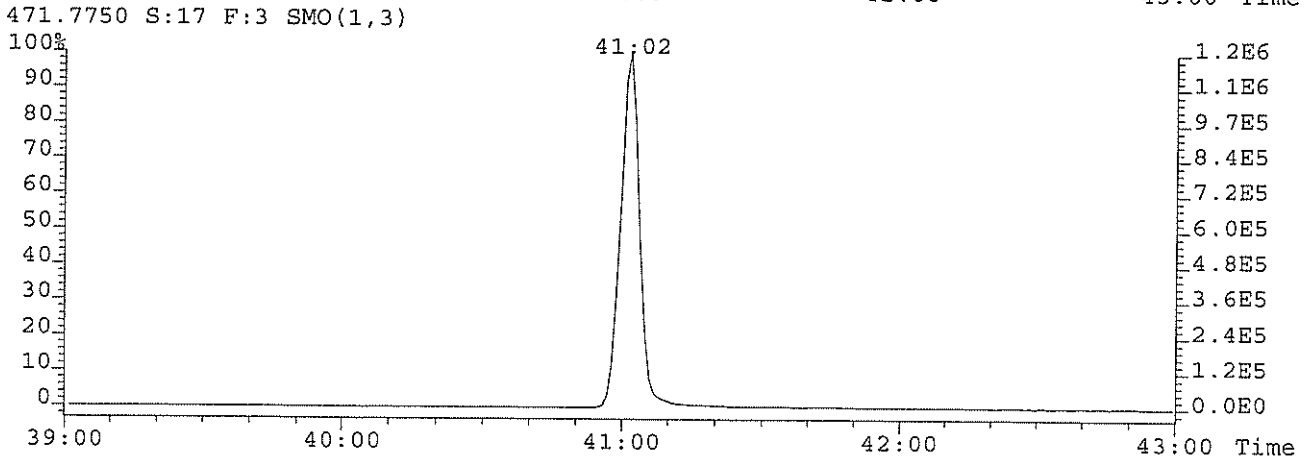
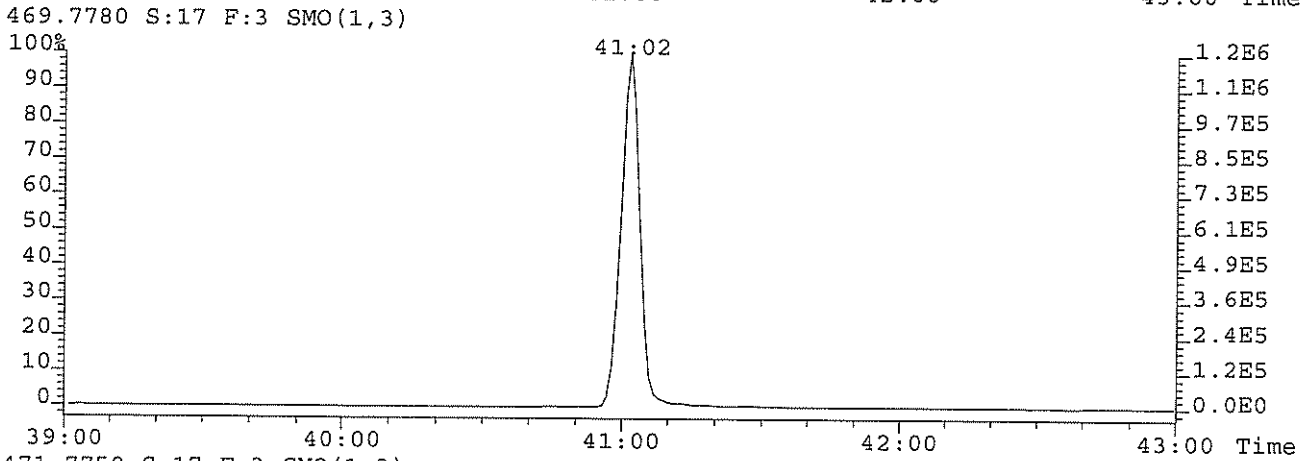
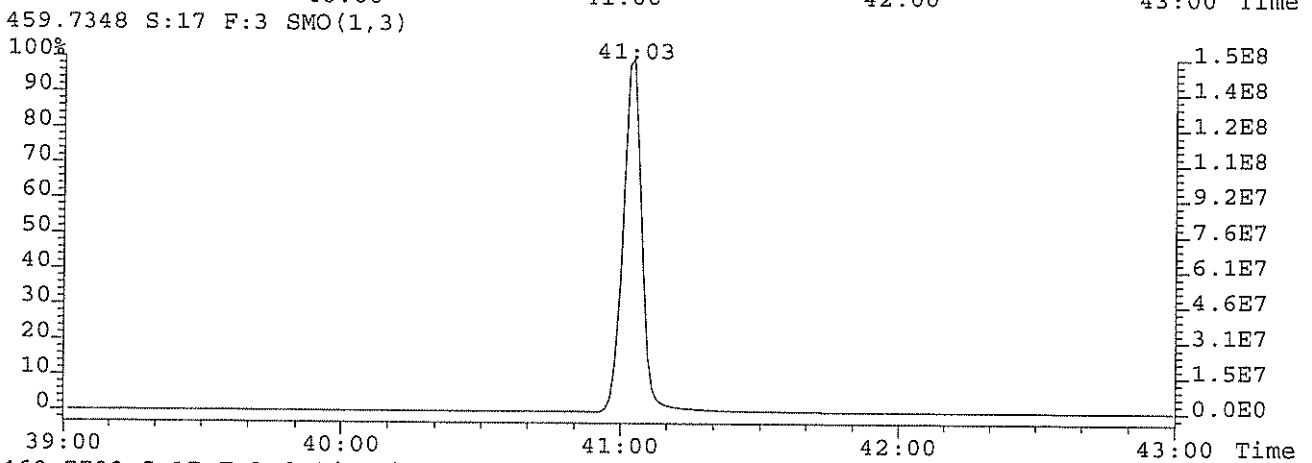
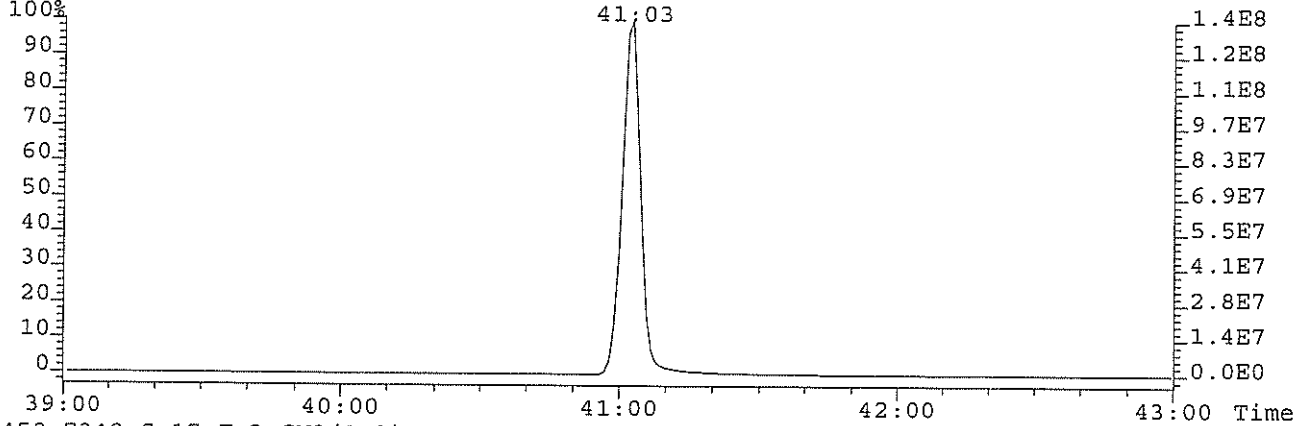
453.7830 S:17 F:3 SMO(1,3)



455.7801 S:17 F:3 SMO(1,3)

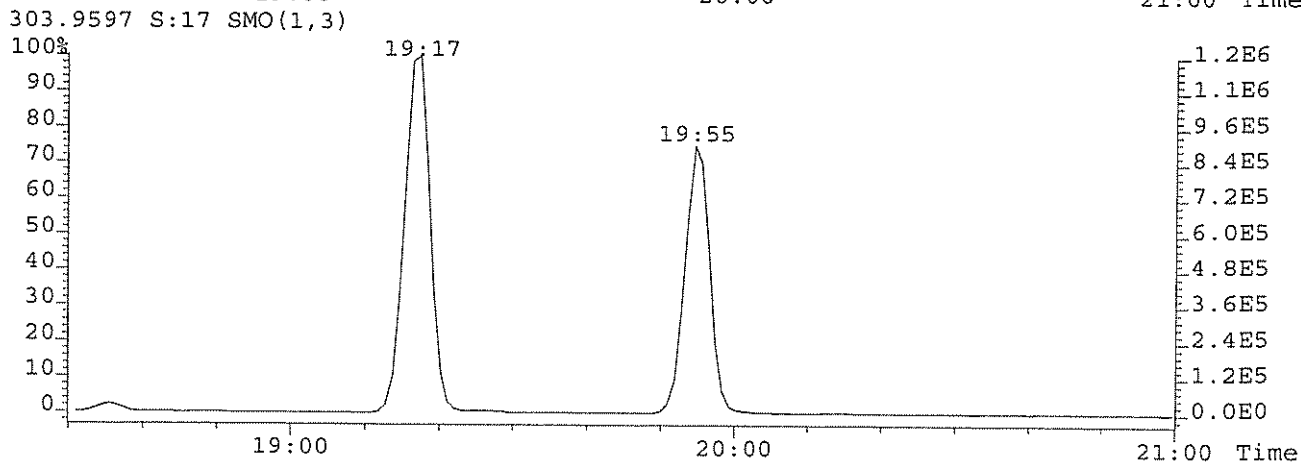
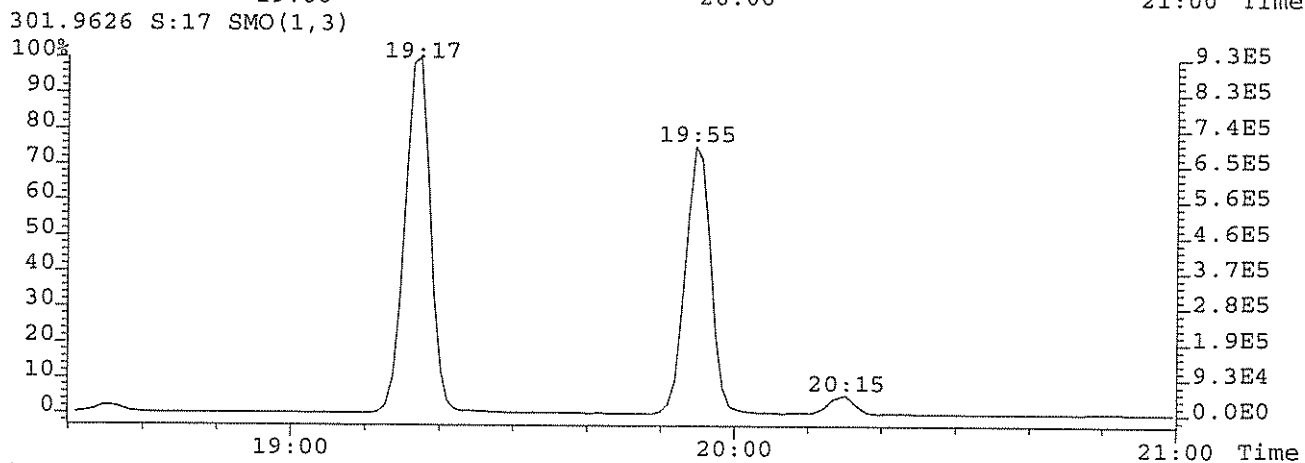
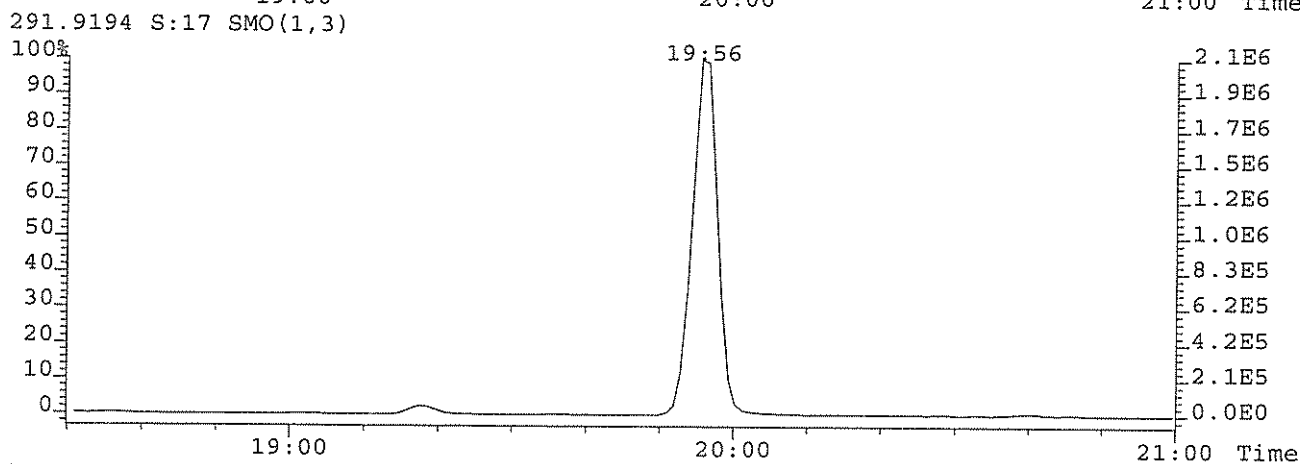
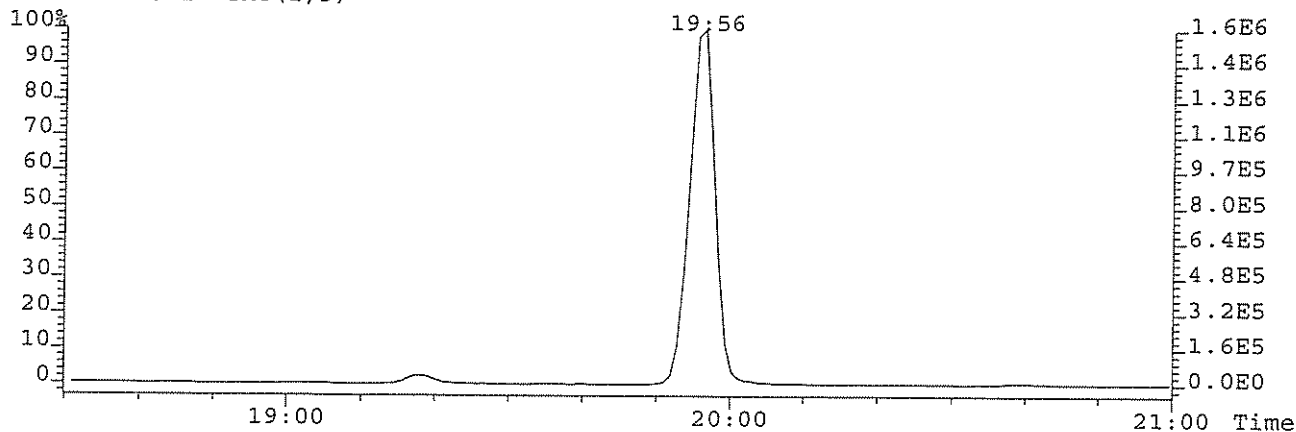


File:130711-2 #1-562 Acq:12-JUL-2013 08:04:39 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0955 3 Exp:RH-PD22



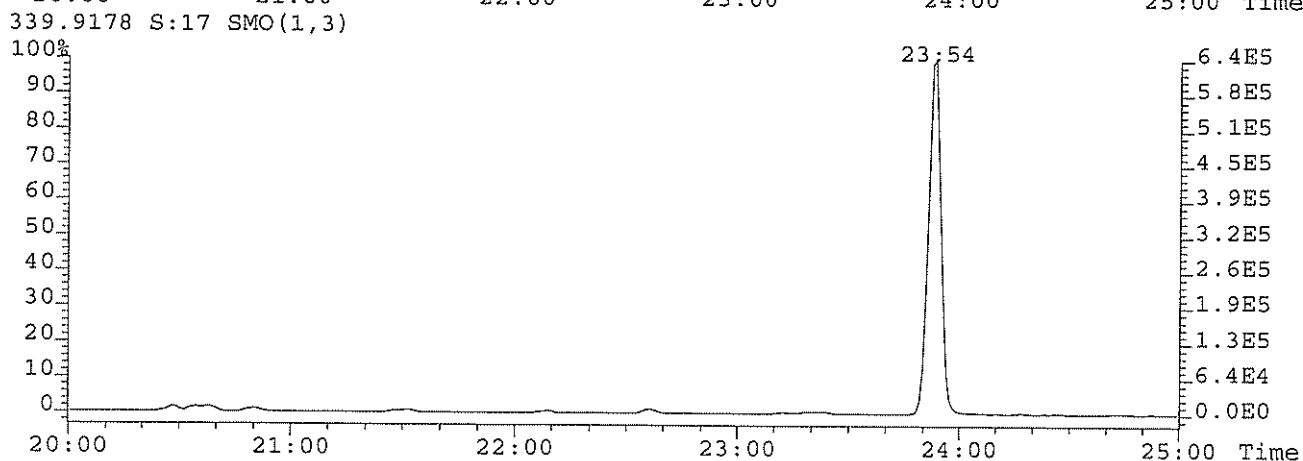
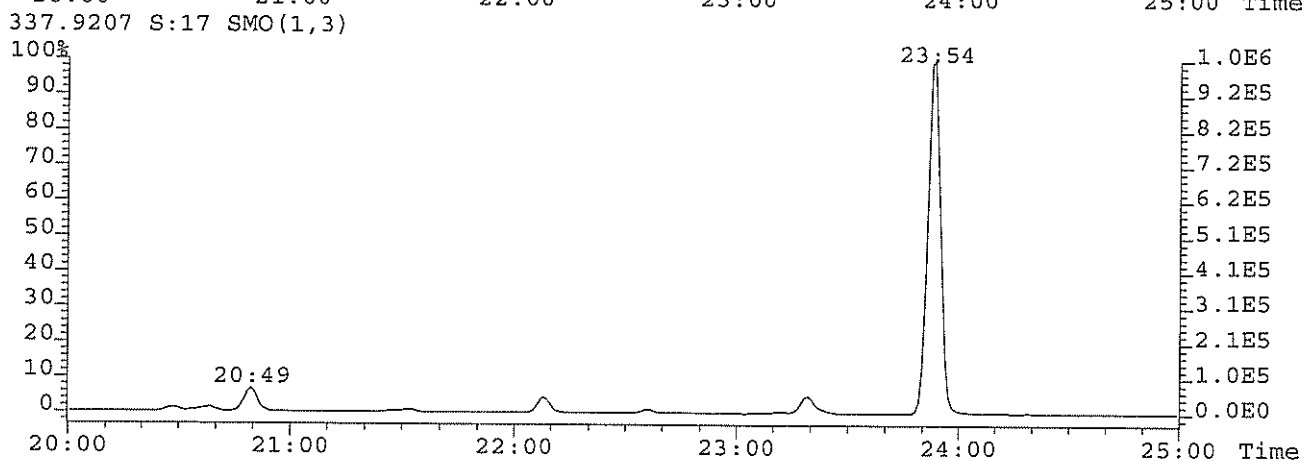
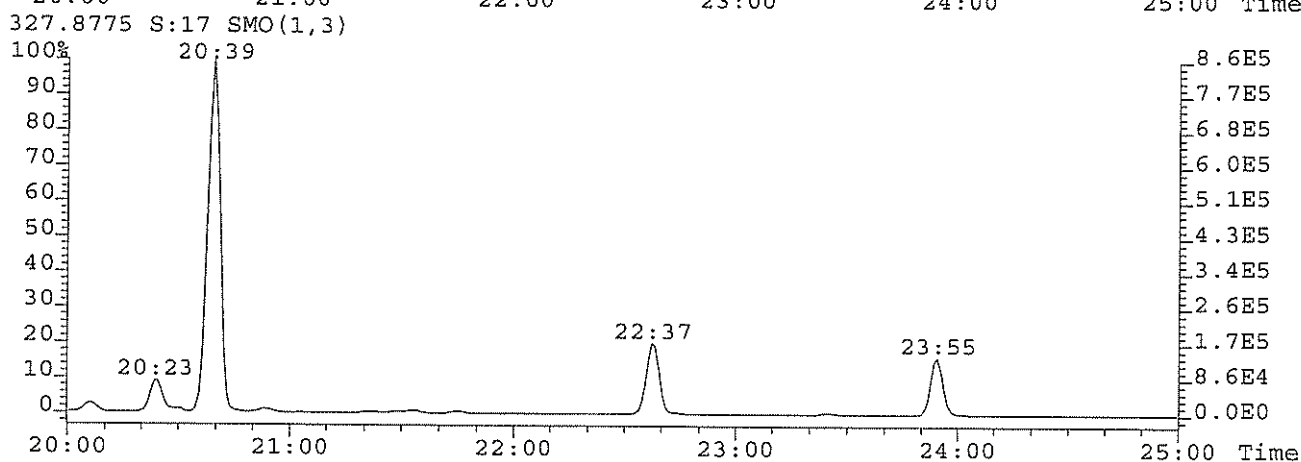
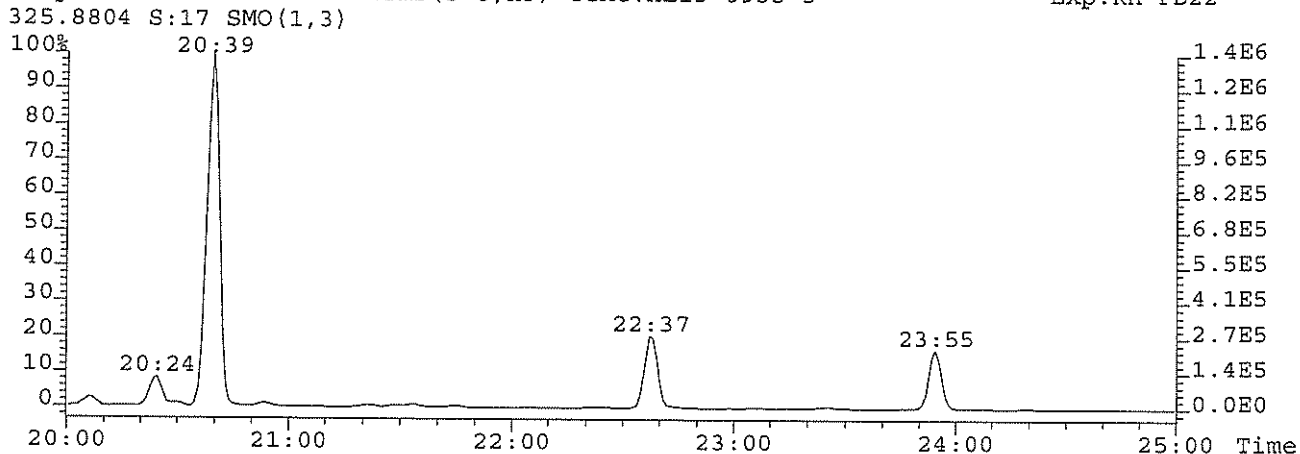
PCDDsクロマトグラム (12)  
(OCDD)

File:130711-2 #1-1430 Acq:12-JUL-2013 08:04:39 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0955 3 Exp:RH-PD22  
289.9224 S:17 SMO(1,3)



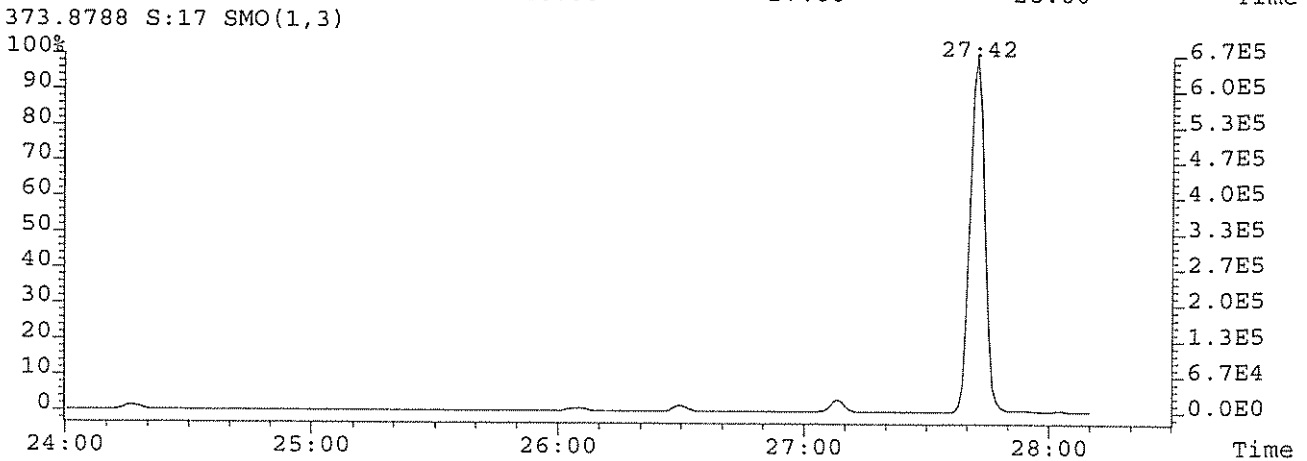
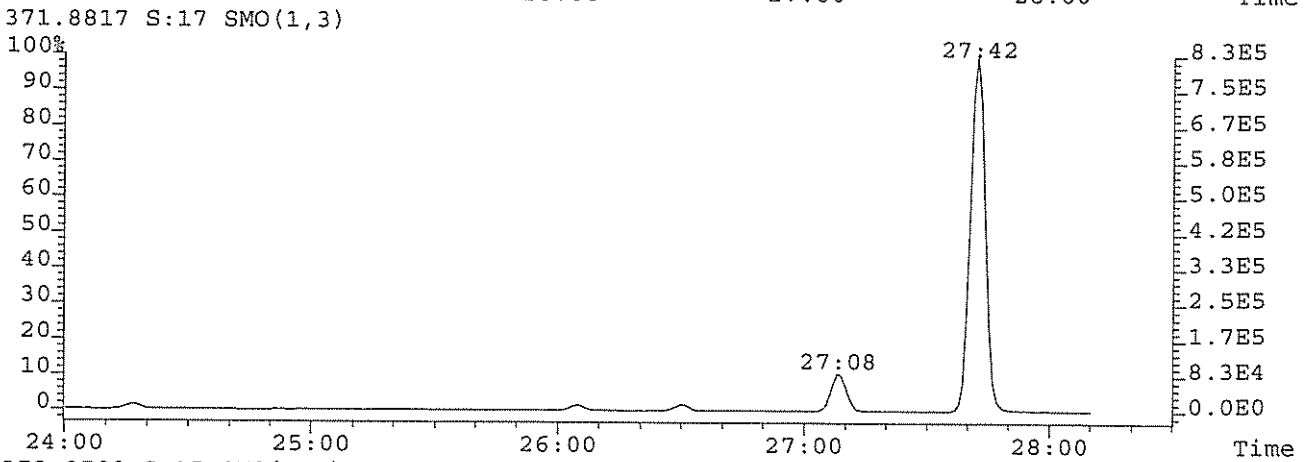
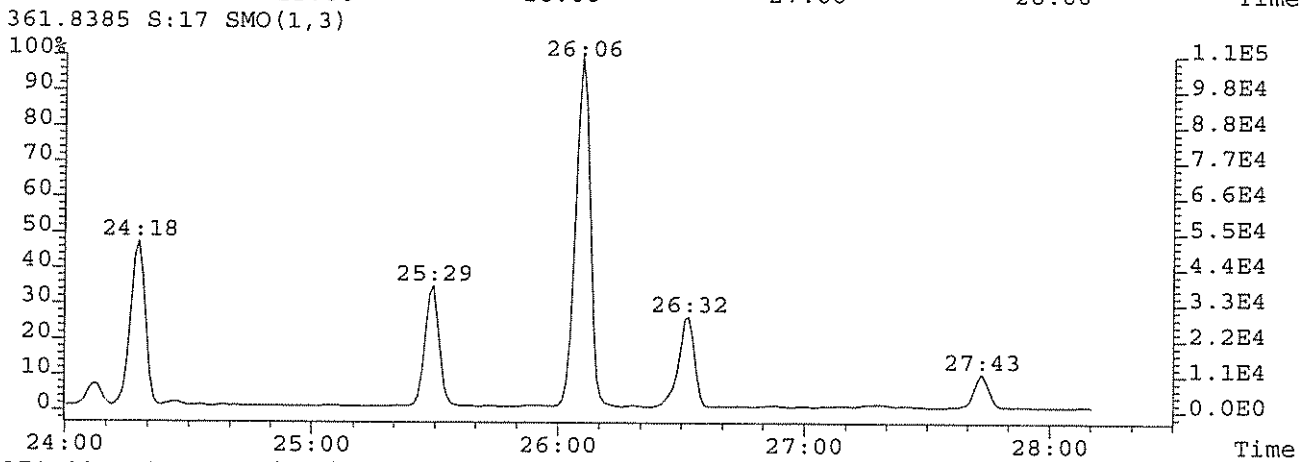
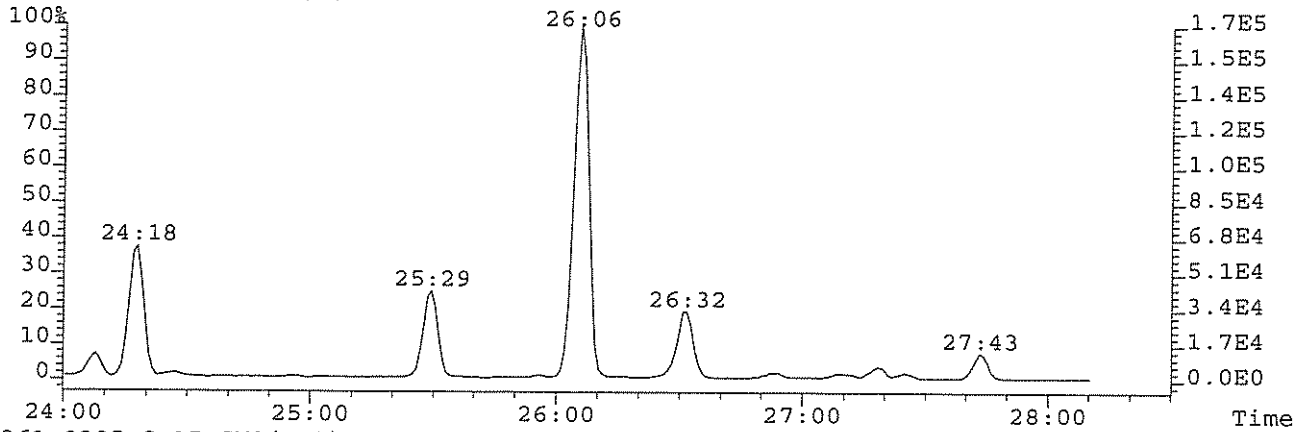
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 08:04:39 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0955 3 Exp:RH-PD22



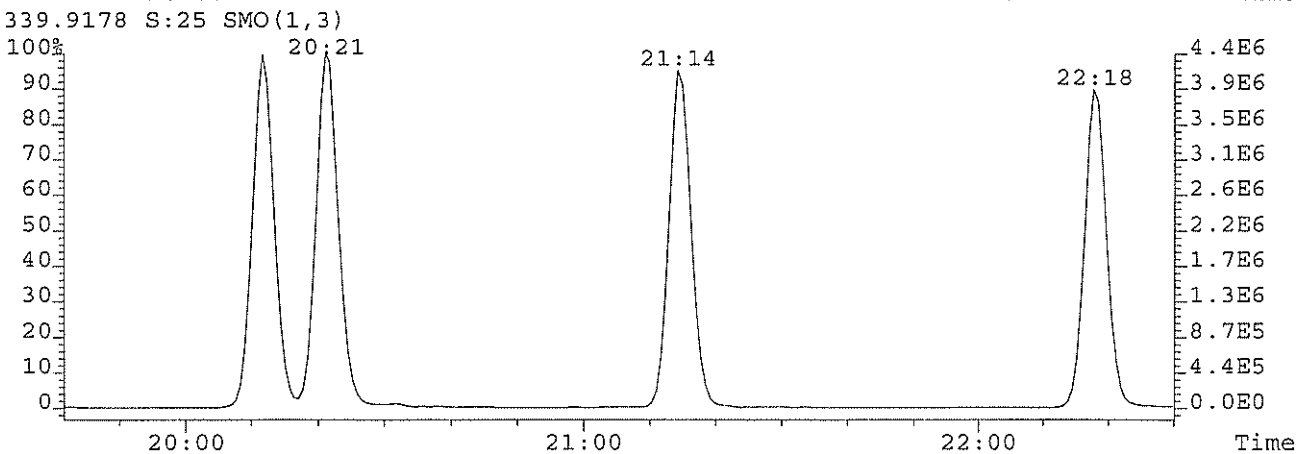
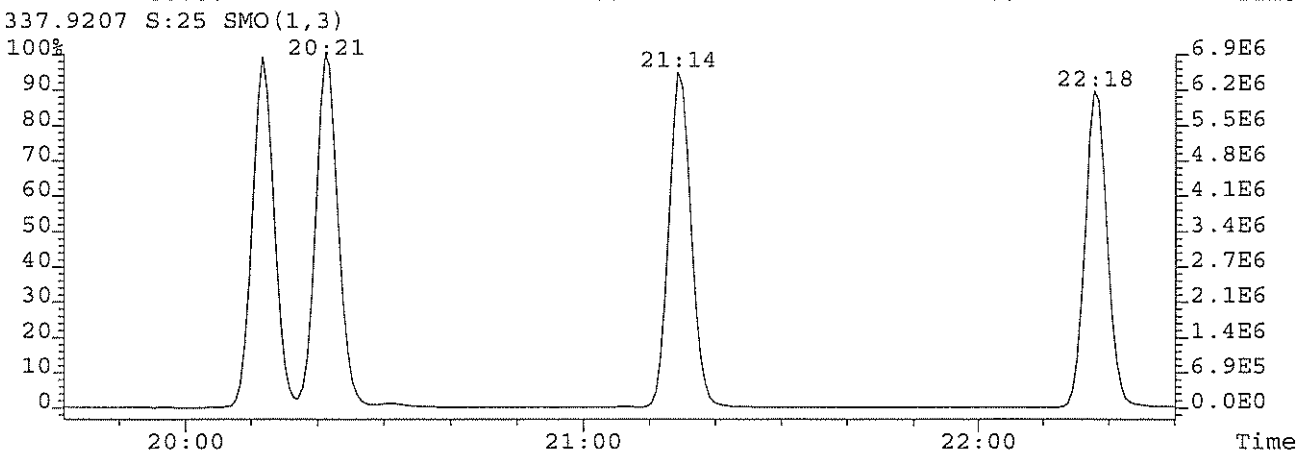
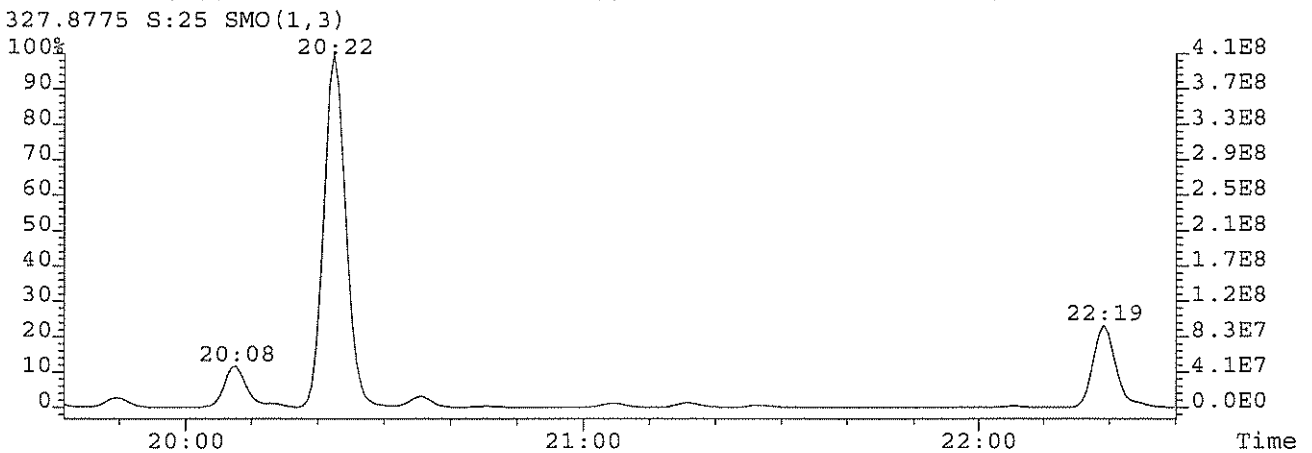
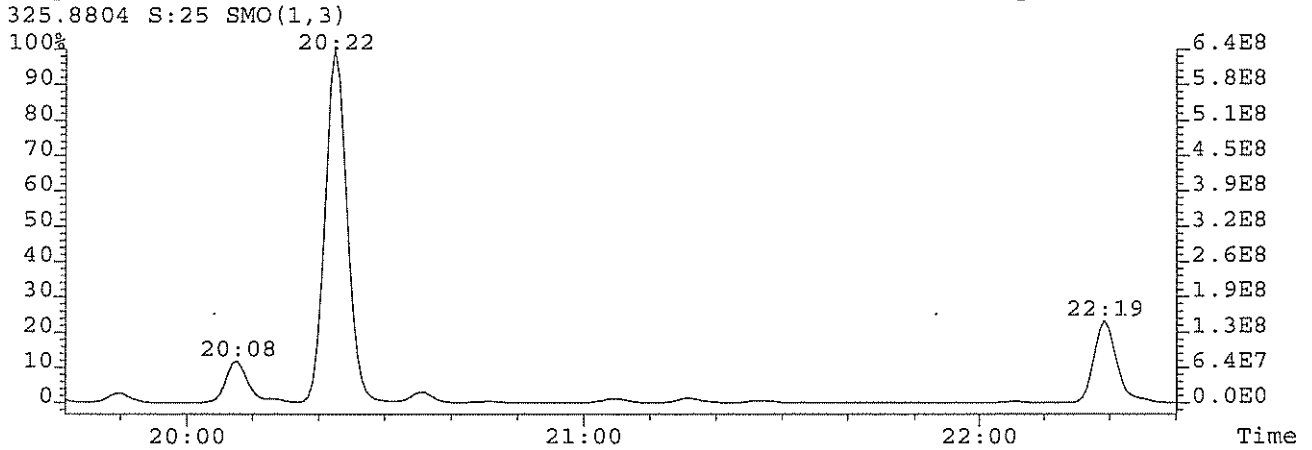
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 08:04:39 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0955 3 Exp:RH-PD22  
359.8415 S:17 SMO(1,3)



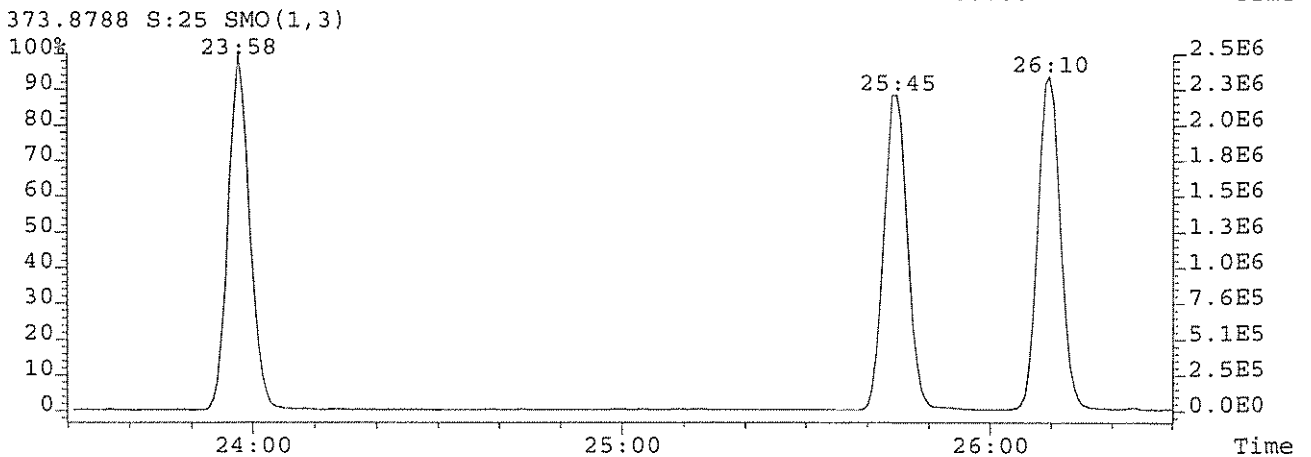
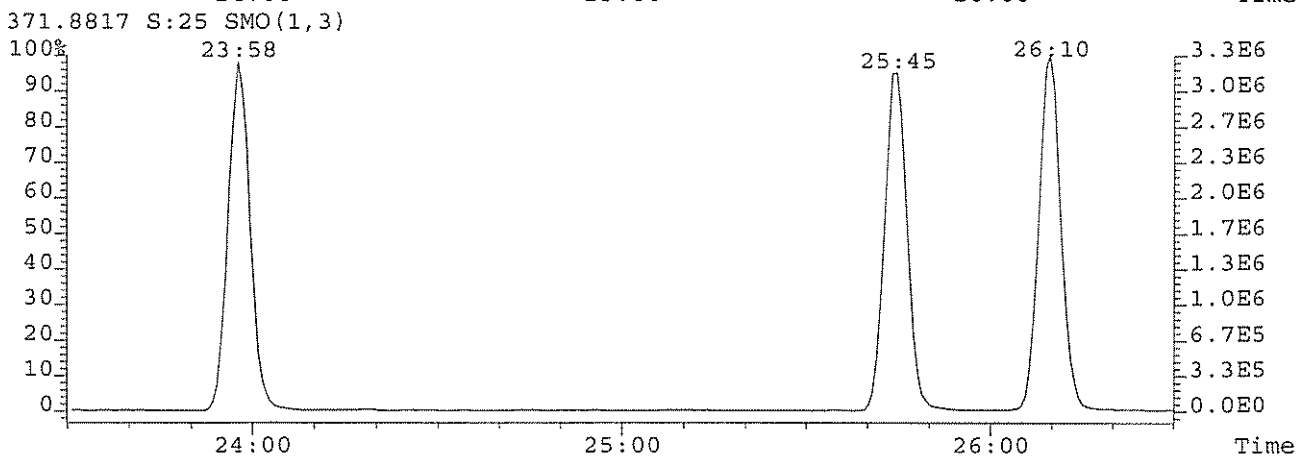
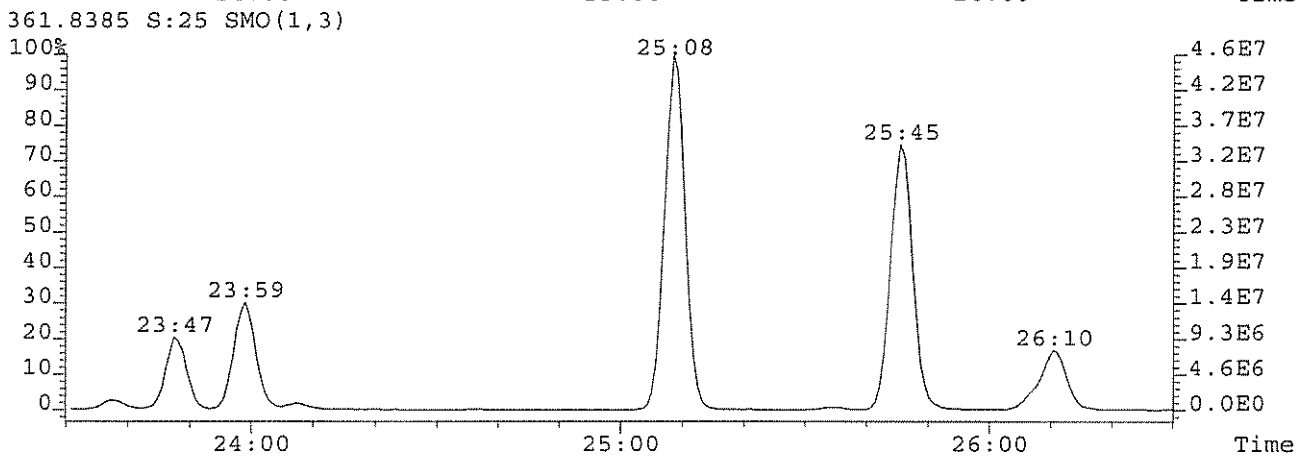
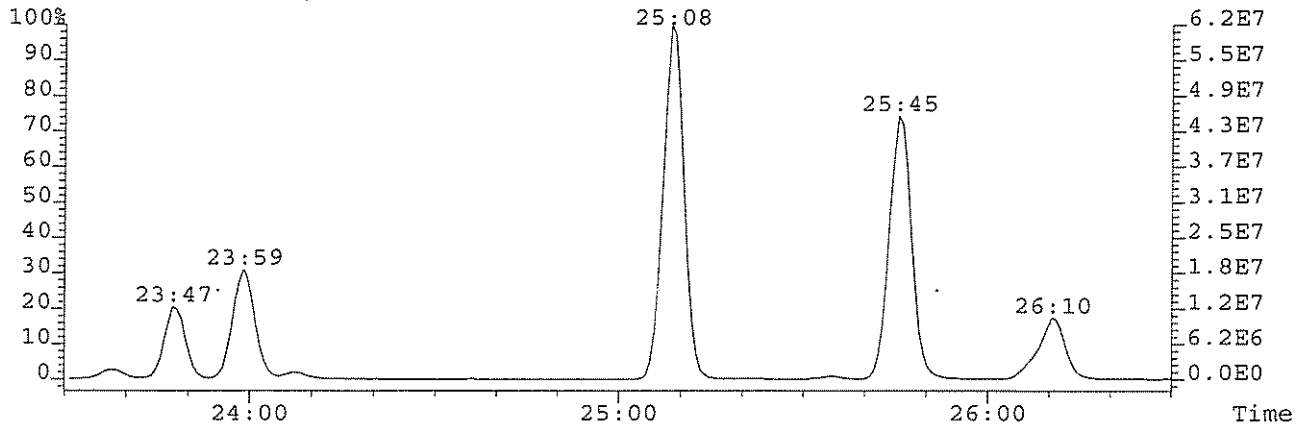
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130713 #1-2898 Acq:14-JUL-2013 04:53:50 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#25 File Text:RH-12ms(mP) Text:XE13 0955 2 Exp:RH-MP11



DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

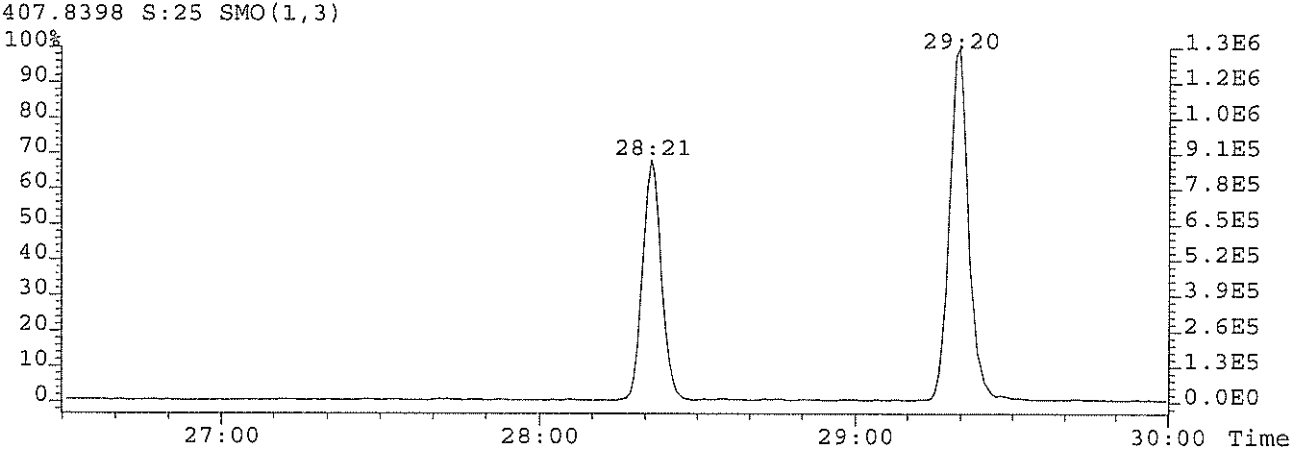
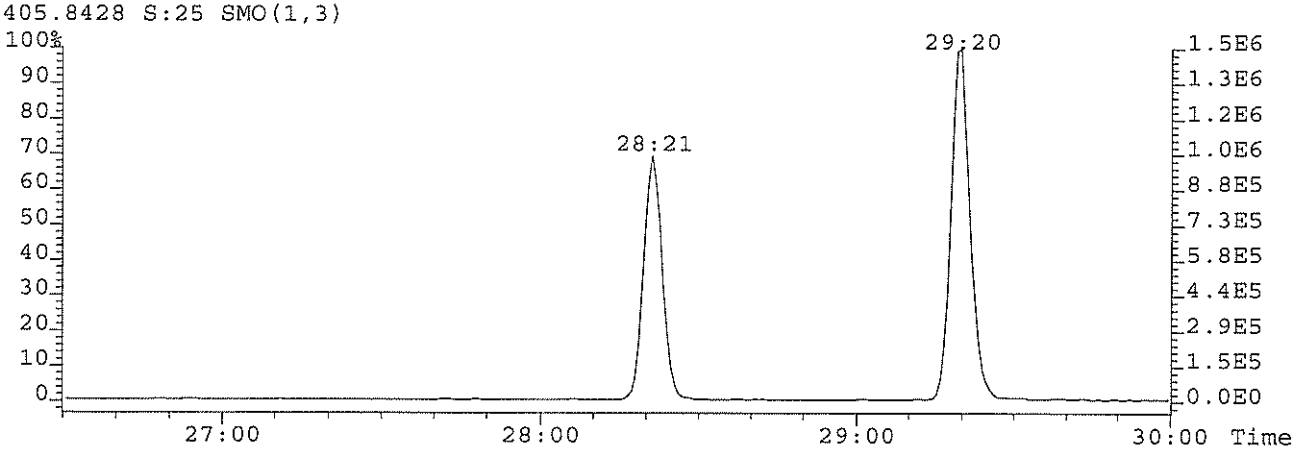
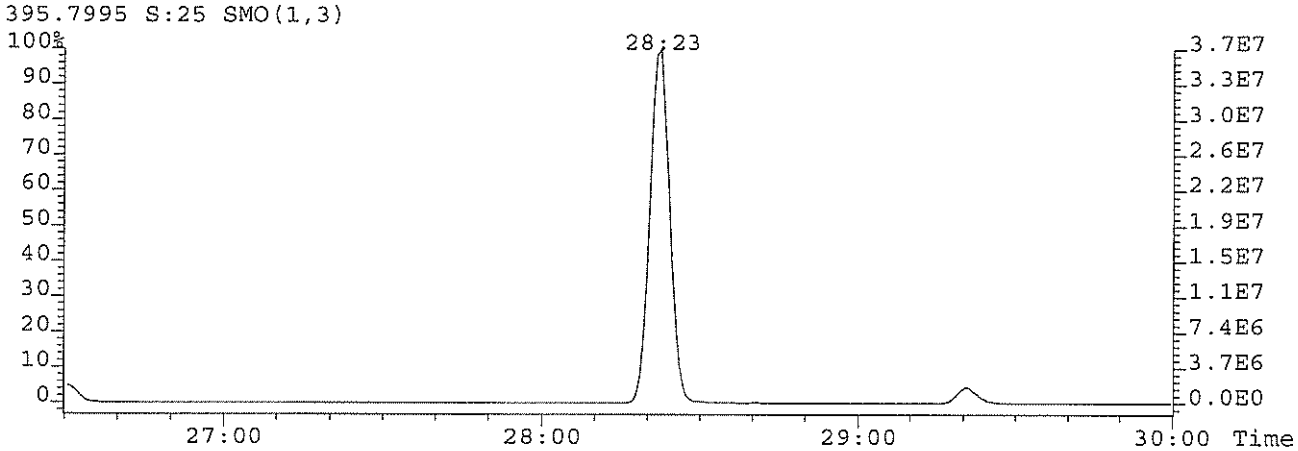
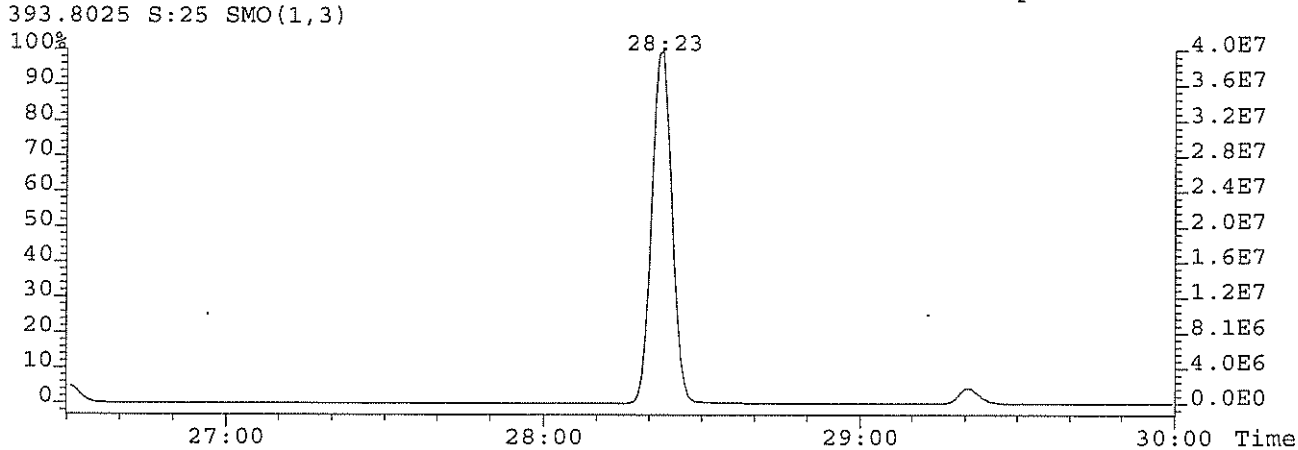
File:130713 #1-2898 Acq:14-JUL-2013 04:53:50 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#25 File Text:RH-12ms(mP) Text:XE13 0955 2 Exp:RH-MP11  
359.8415 S:25 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)



File:130713 #1-2898 Acq:14-JUL-2013 04:53:50 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#25 File Text:RH-12ms(mP) Text:XE13 0955 2 Exp:RH-MP11

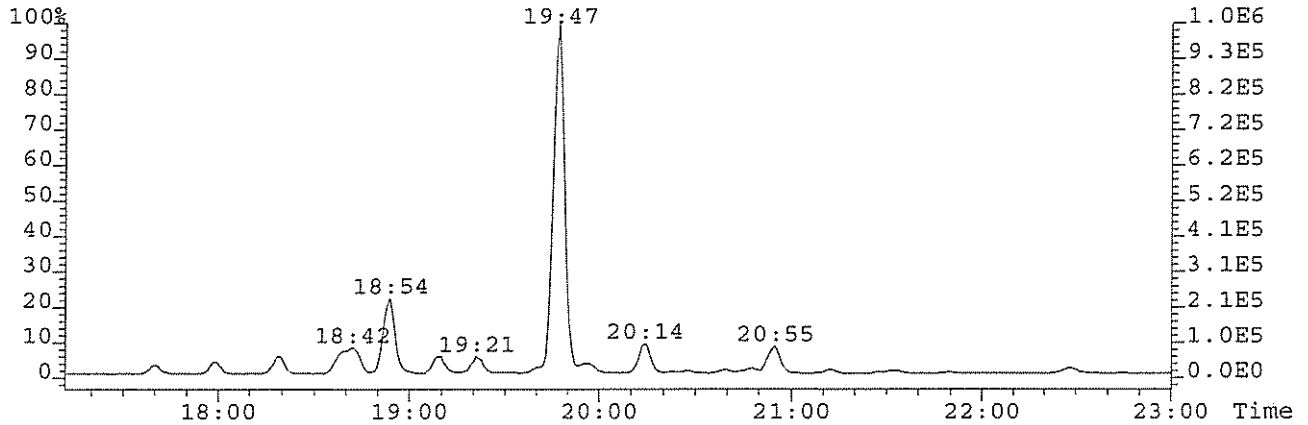


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

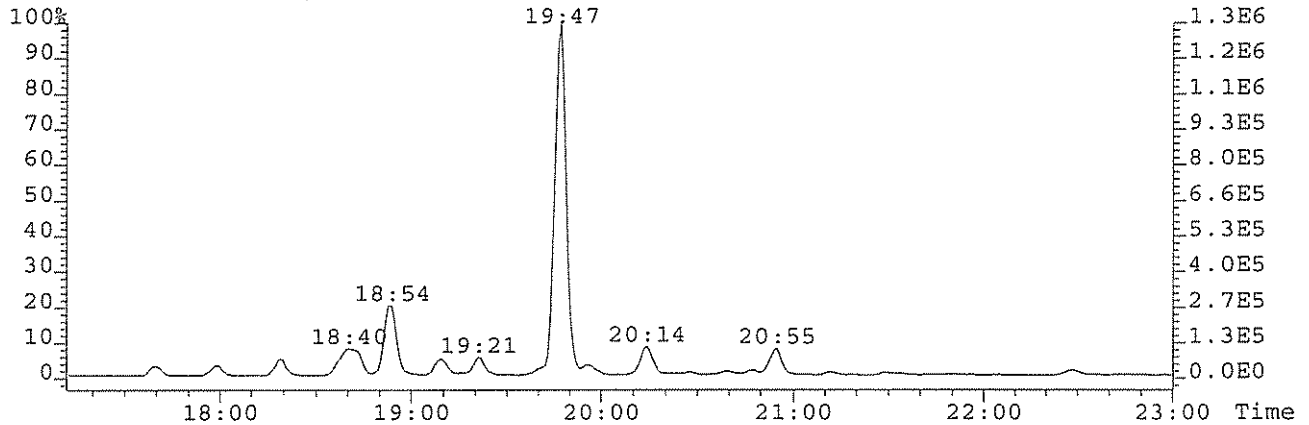
試料管理番号	XE 130956
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.10

File:130712-2 #1-1578 Acq:13-JUL-2013 02:09:09 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:BPX-DXN(4-6DXN) Text:XEI3 0956 Exp:BPX04

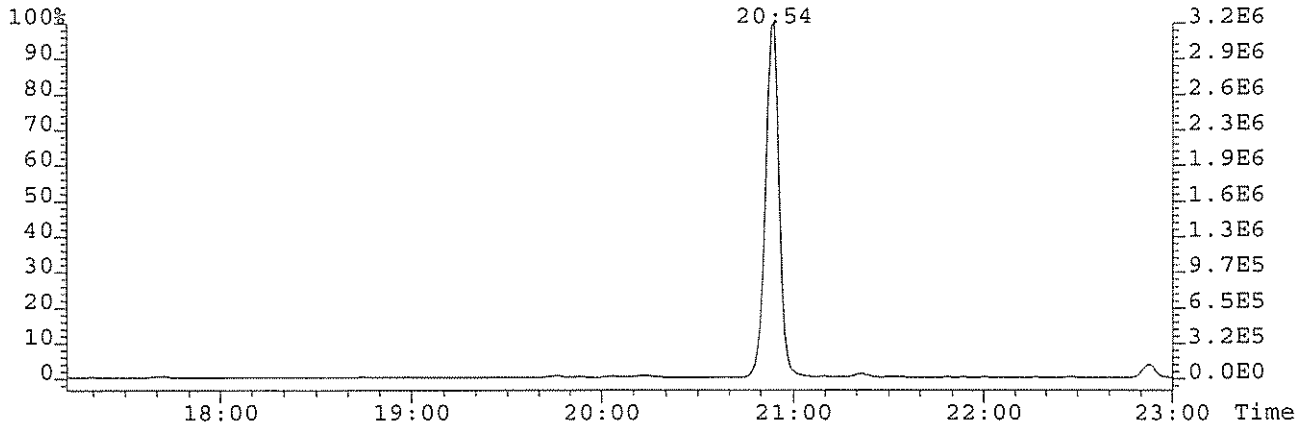
303.9016 S:13 SMO(1,3)



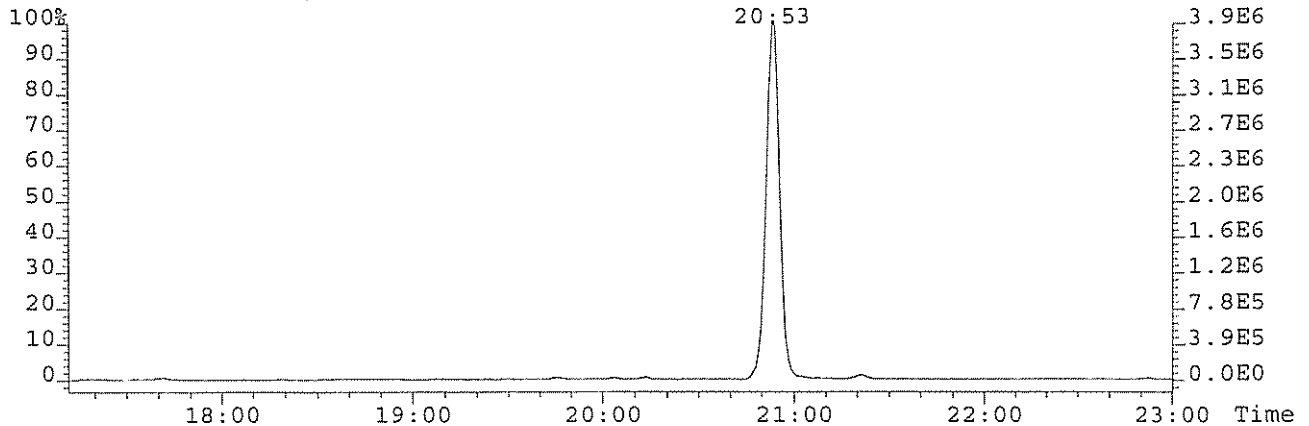
305.8987 S:13 SMO(1,3)



315.9419 S:13 SMO(1,3)



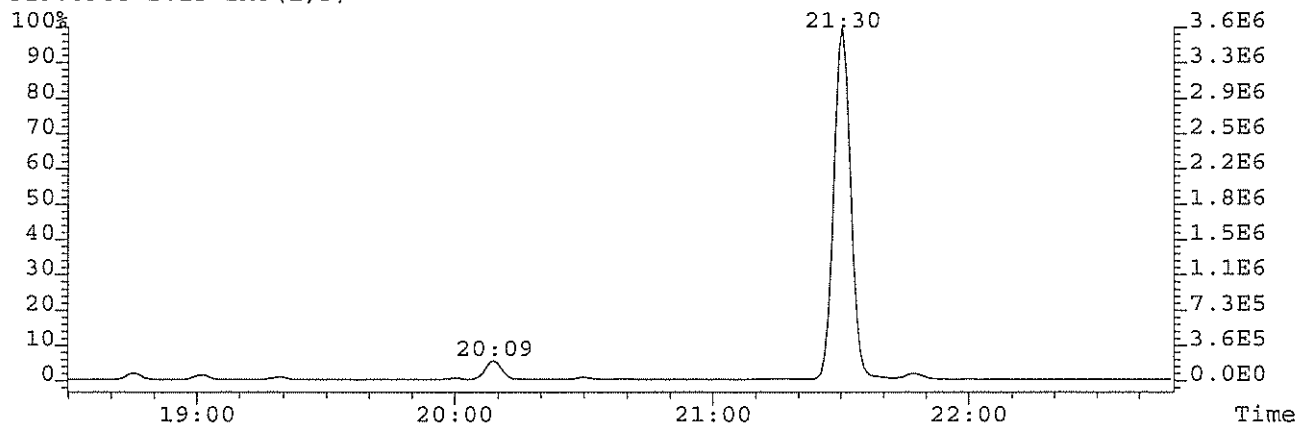
317.9389 S:13 SMO(1,3)



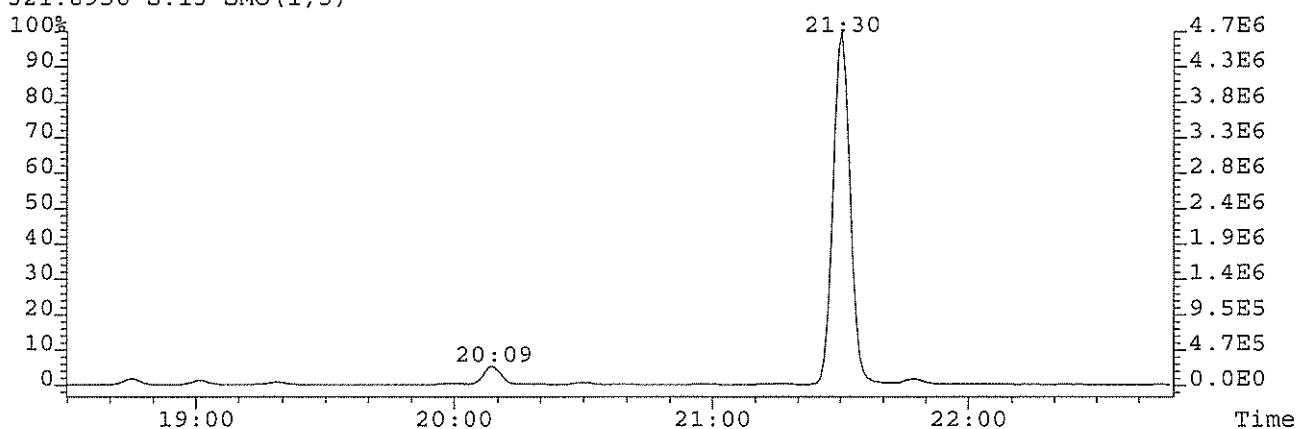
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 02:09:09 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:BPX-DXN(4-6DXN) Text:XE13 0956 Exp:BPX04

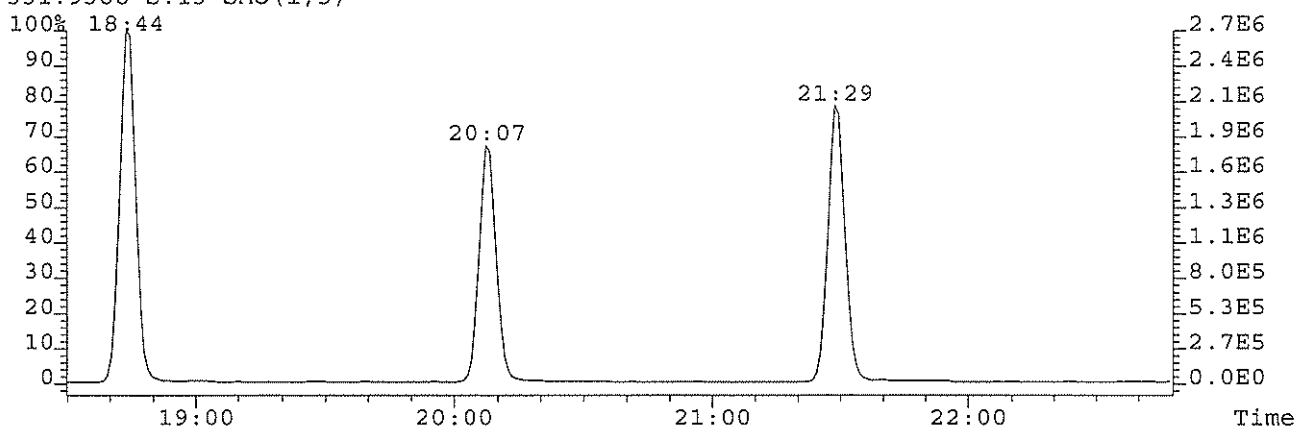
319.8965 S:13 SMO(1,3)



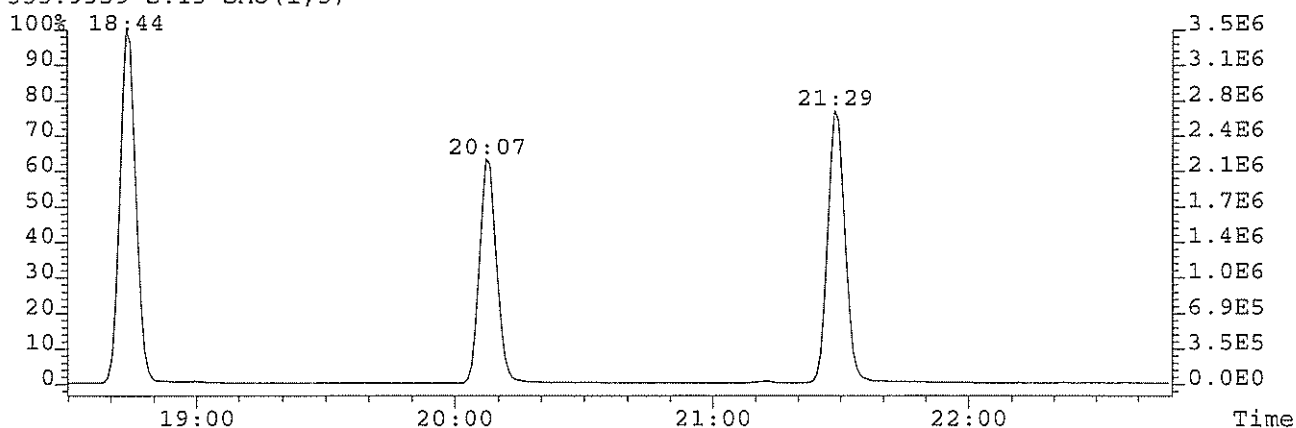
321.8936 S:13 SMO(1,3)



331.9368 S:13 SMO(1,3)



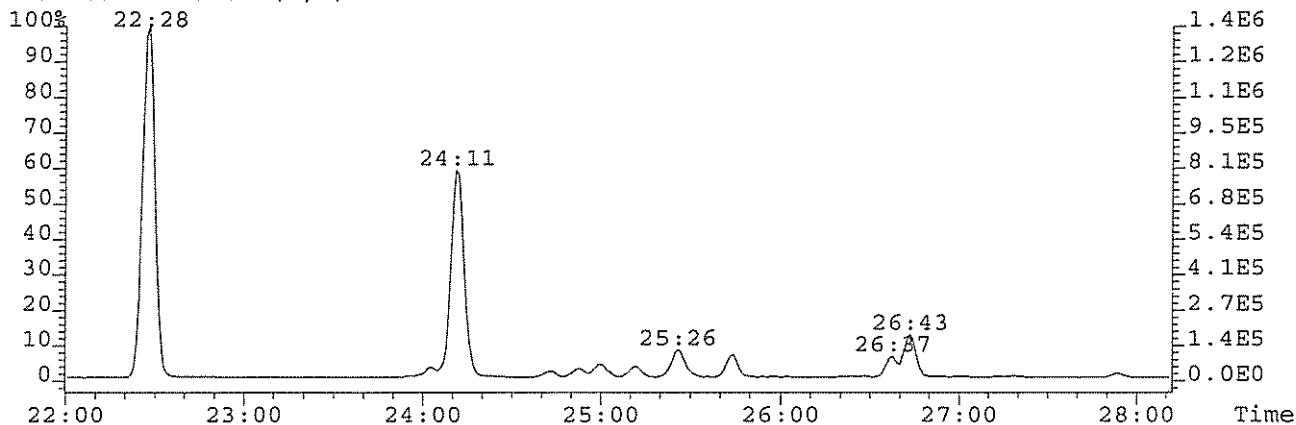
333.9339 S:13 SMO(1,3)



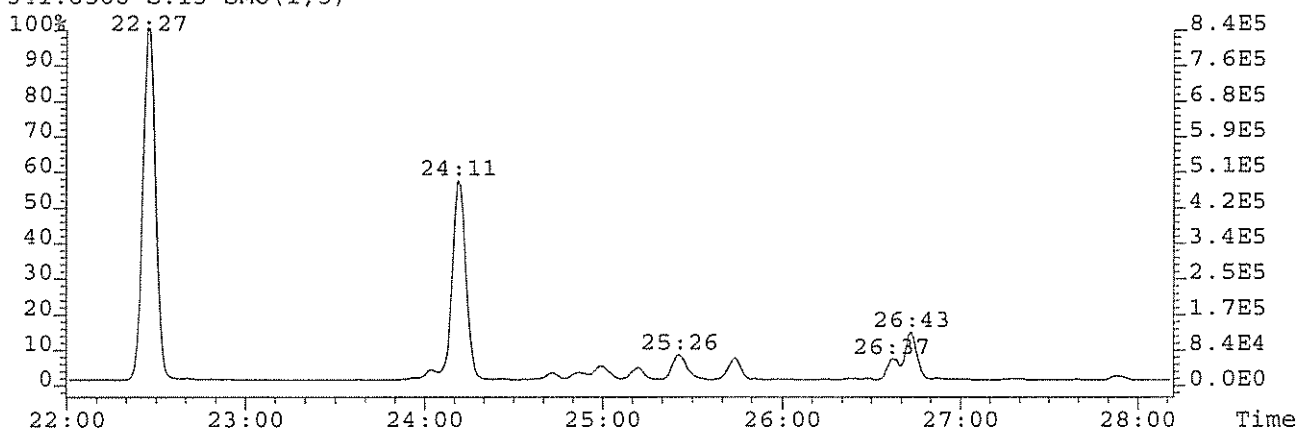
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130712-2 #1-1578 Acq:13-JUL-2013 02:09:09 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:BPX-DXN(4-6DXN) Text:XE13 0956 Exp:BPX04

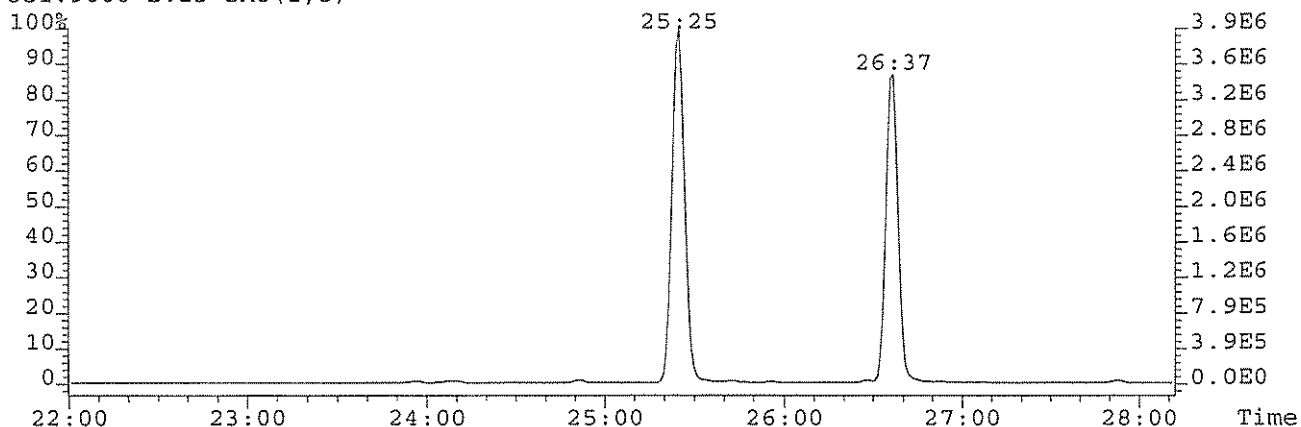
339.8597 S:13 SMO(1,3)



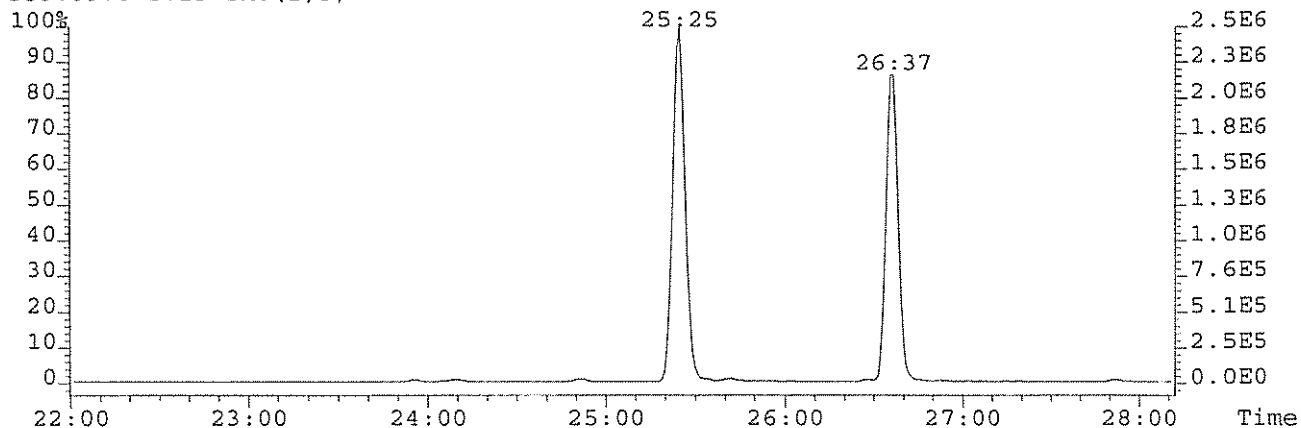
341.8568 S:13 SMO(1,3)



351.9000 S:13 SMO(1,3)



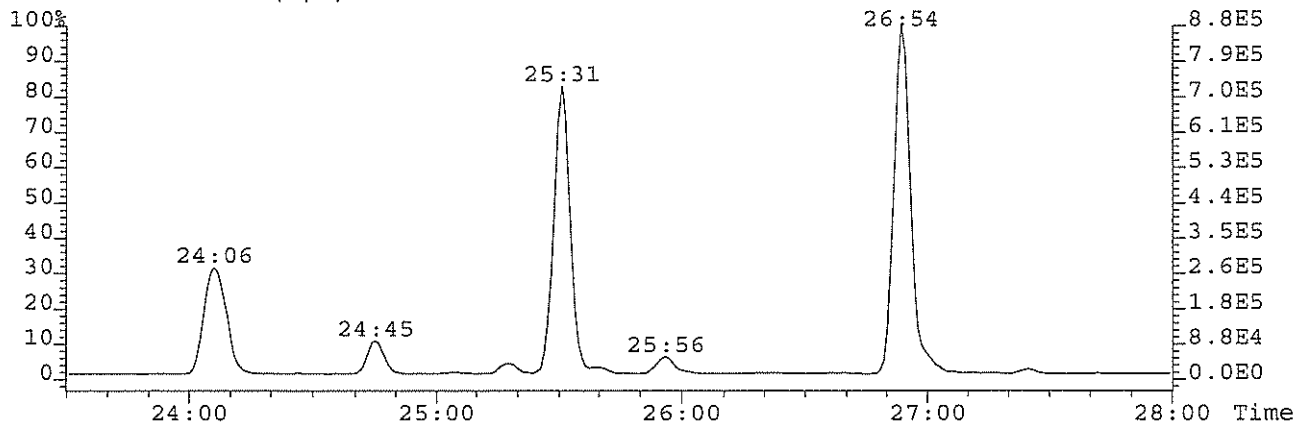
353.8970 S:13 SMO(1,3)



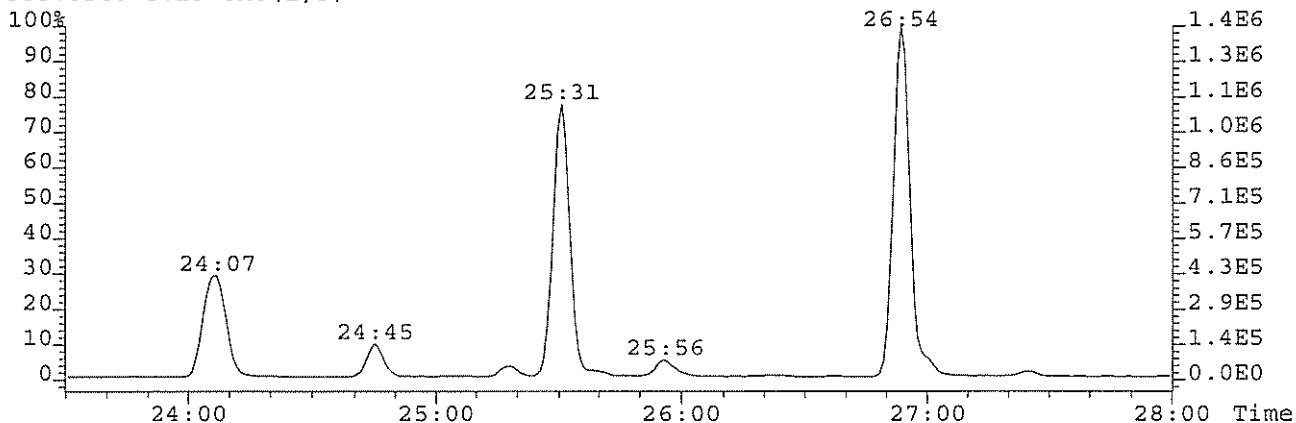
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 02:09:09 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:BPX-DXN(4-6DXN) Text:XE13 0956 Exp:BPX04

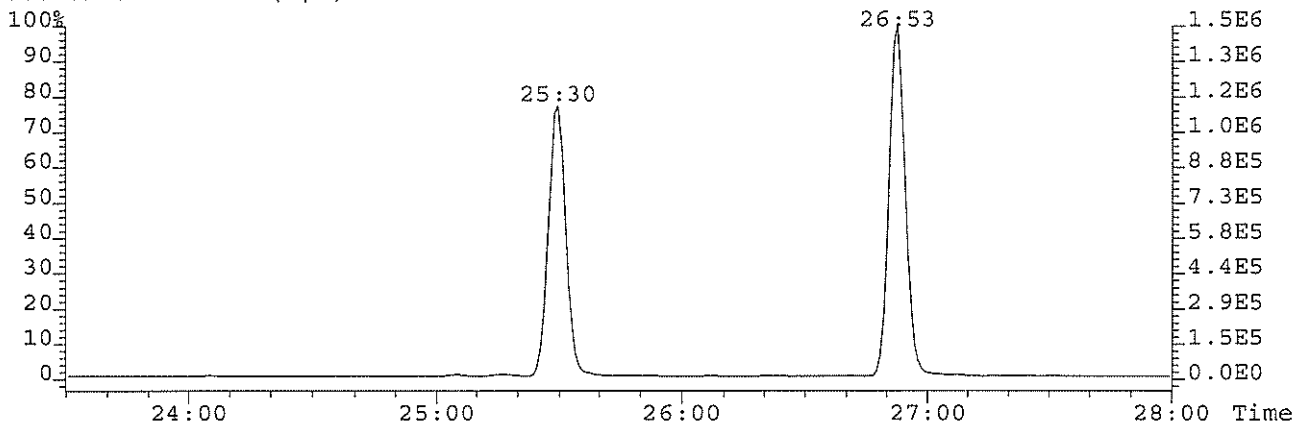
353.8576 S:13 SMO(1,3)



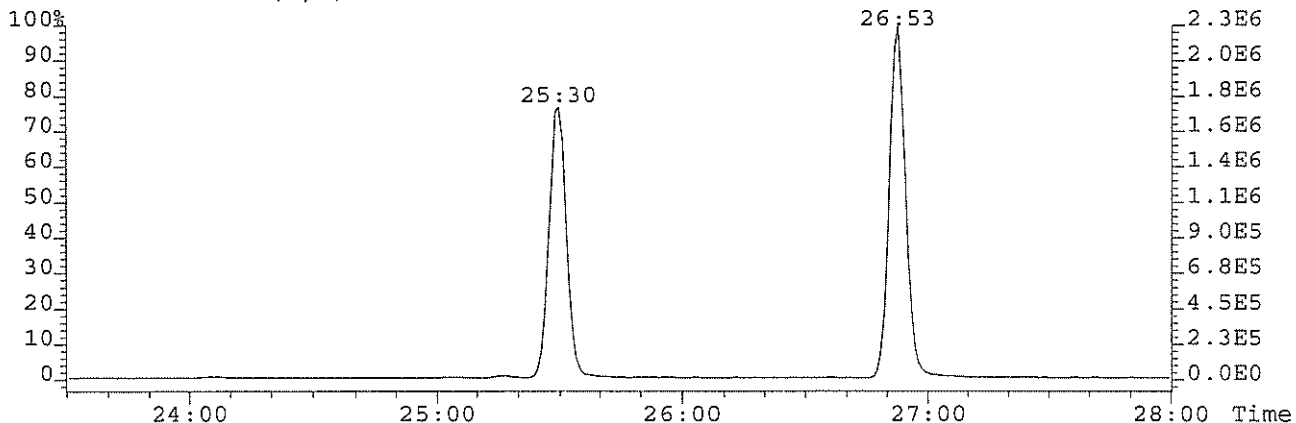
355.8546 S:13 SMO(1,3)



365.8978 S:13 SMO(1,3)



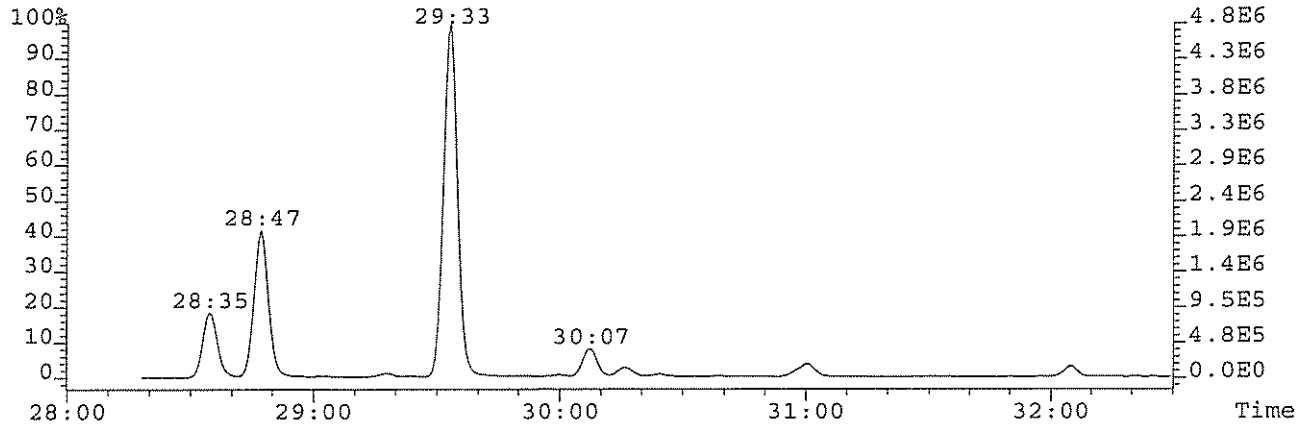
367.8949 S:13 SMO(1,3)



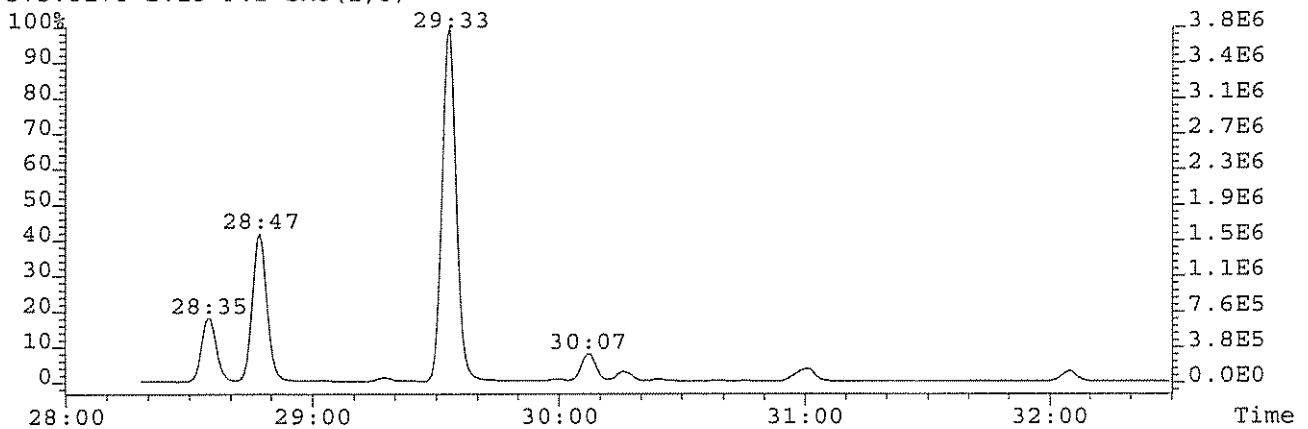
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130712-2 #1-1117 Acq:13-JUL-2013 02:09:09 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:BPX-DXN(4-6DXN) Text:XE13 0956 Exp:BPX04

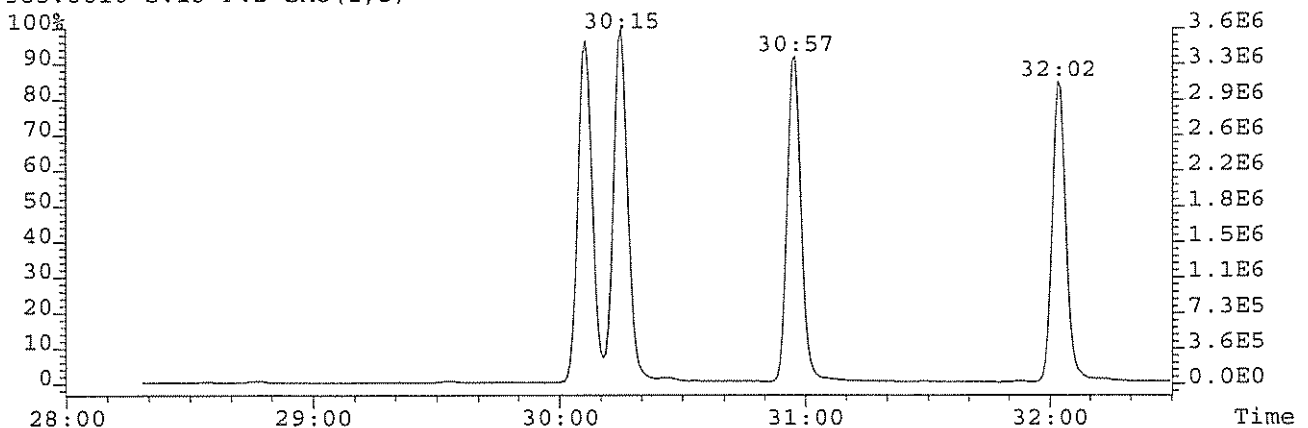
373.8207 S:13 F:2 SMO(1,3)



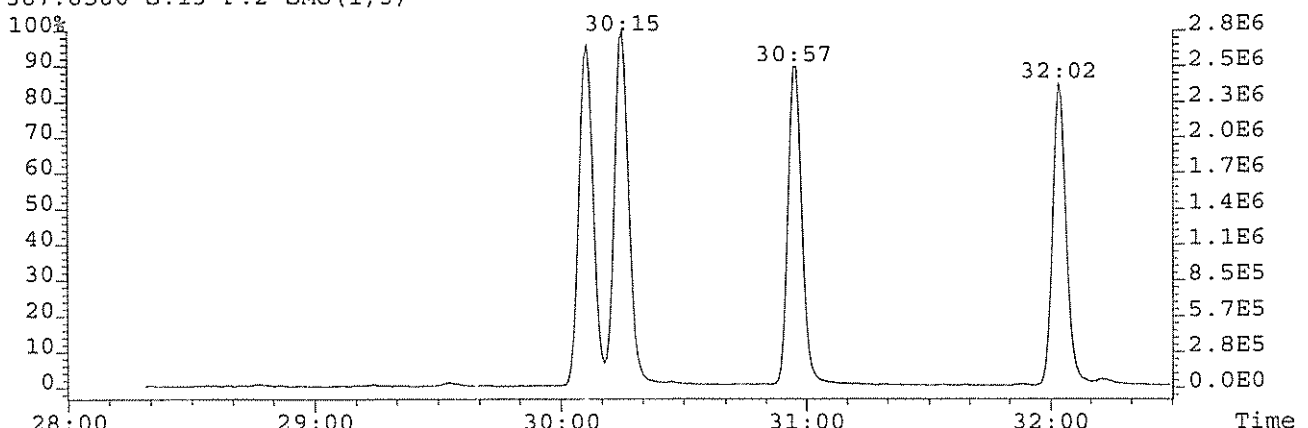
375.8178 S:13 F:2 SMO(1,3)



385.8610 S:13 F:2 SMO(1,3)



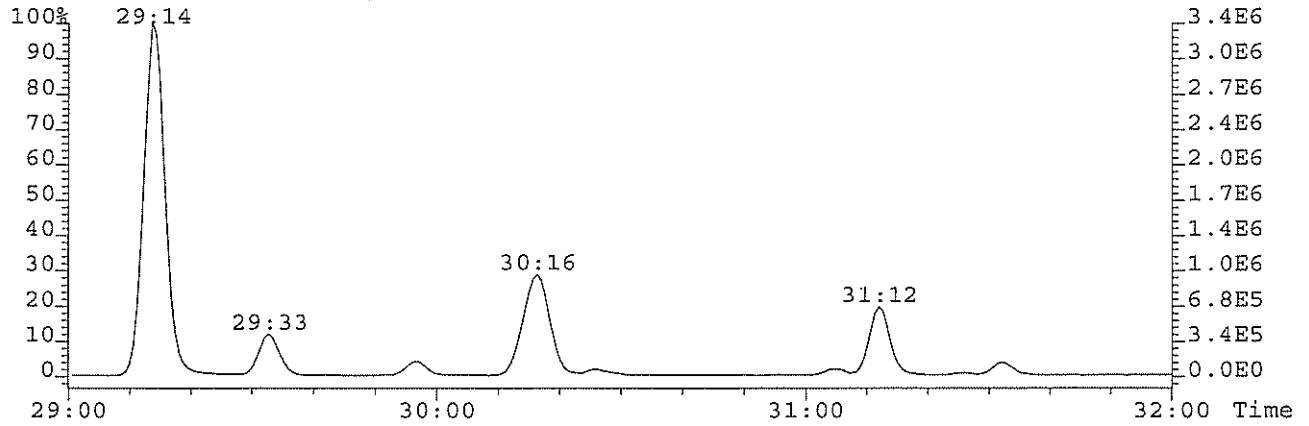
387.8580 S:13 F:2 SMO(1,3)



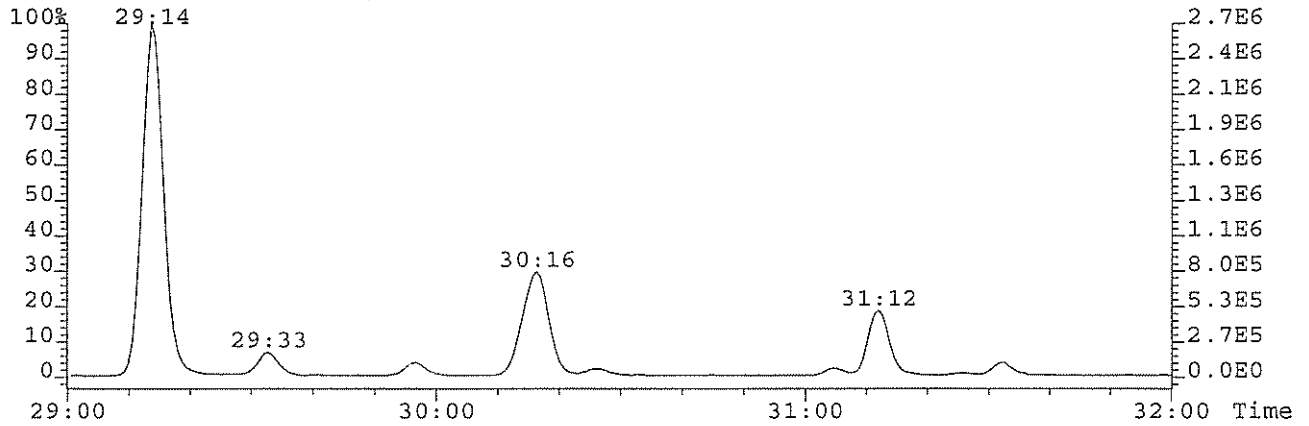
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1117 Acq:13-JUL-2013 02:09:09 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:BPX-DXN(4-6DXN) Text:XE13 0956 Exp:BPX04

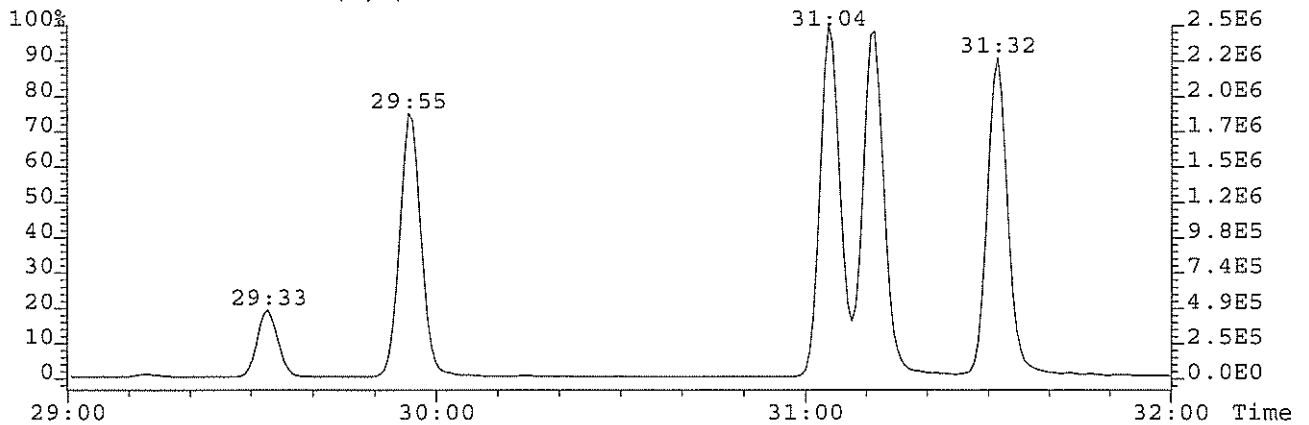
389.8156 S:13 F:2 SMO(1,3)



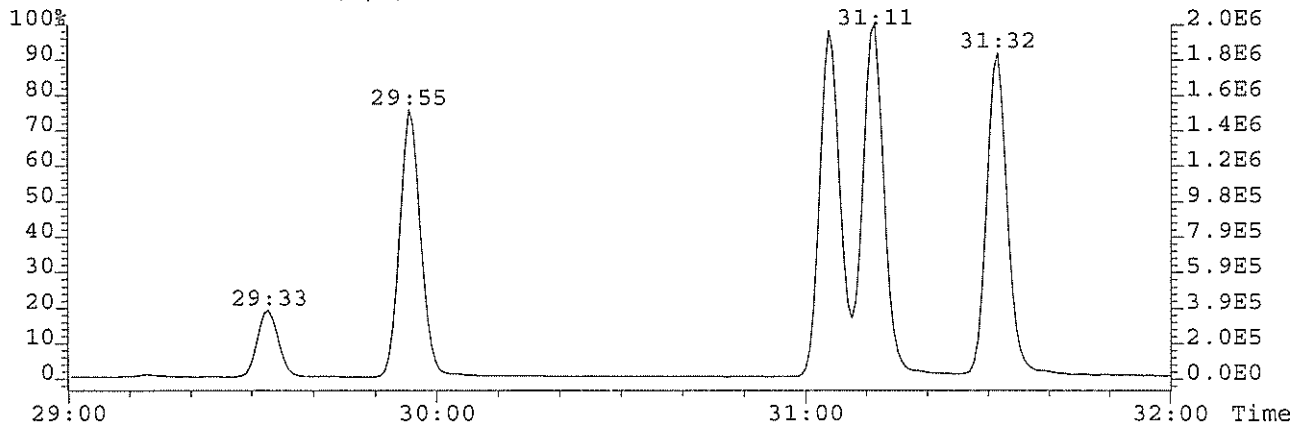
391.8127 S:13 F:2 SMO(1,3)



401.8559 S:13 F:2 SMO(1,3)



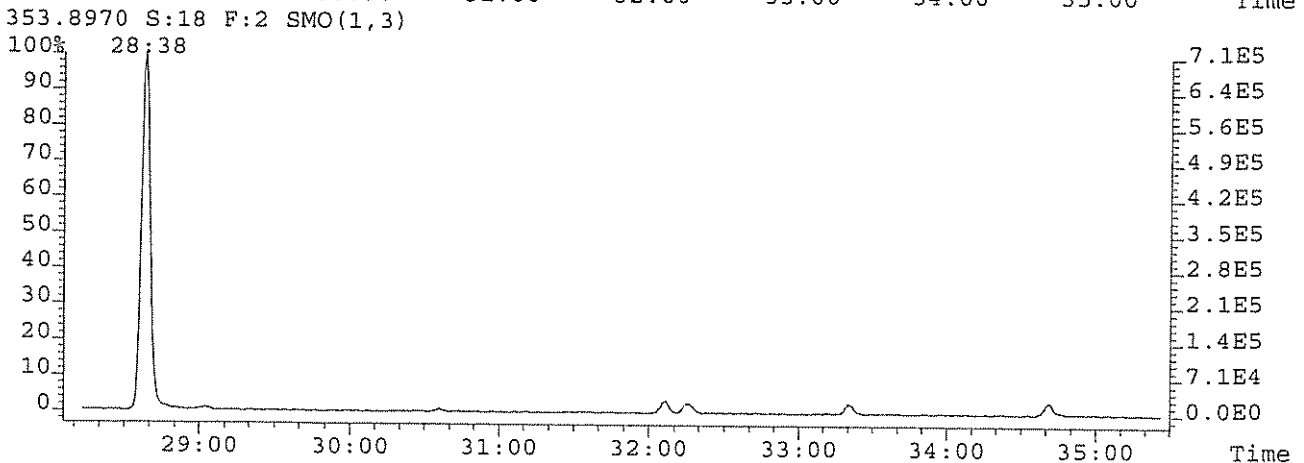
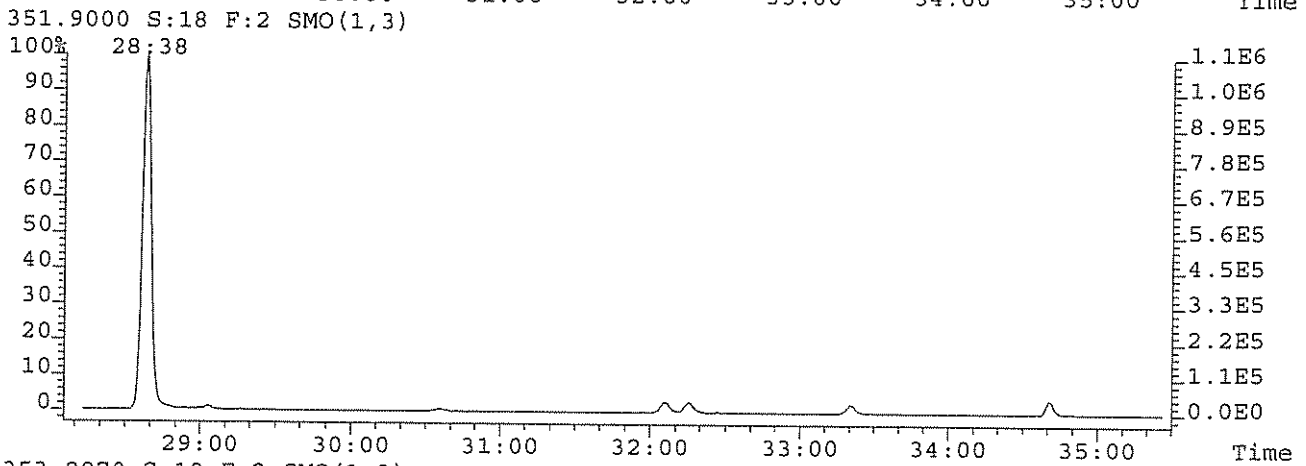
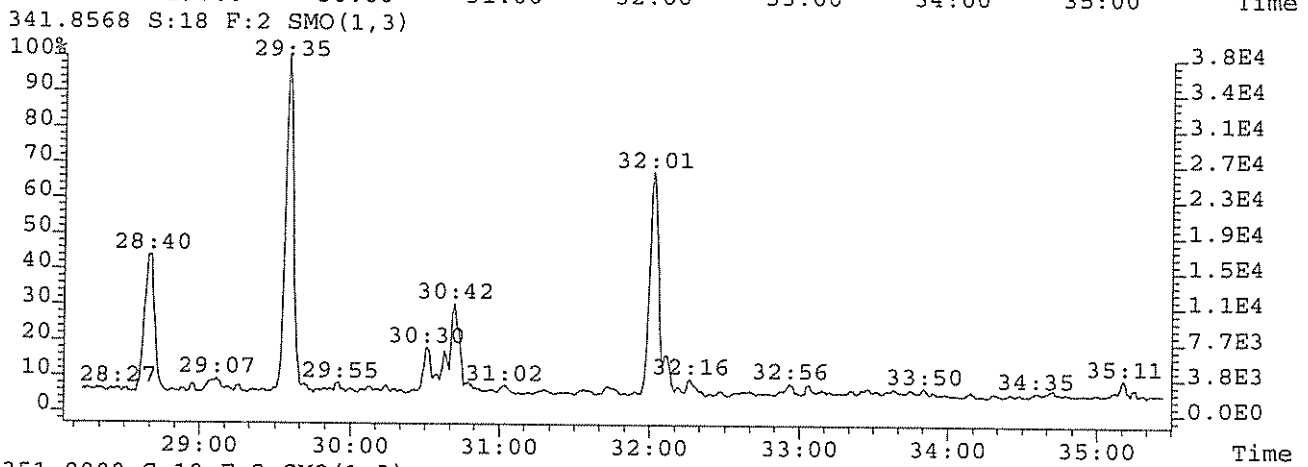
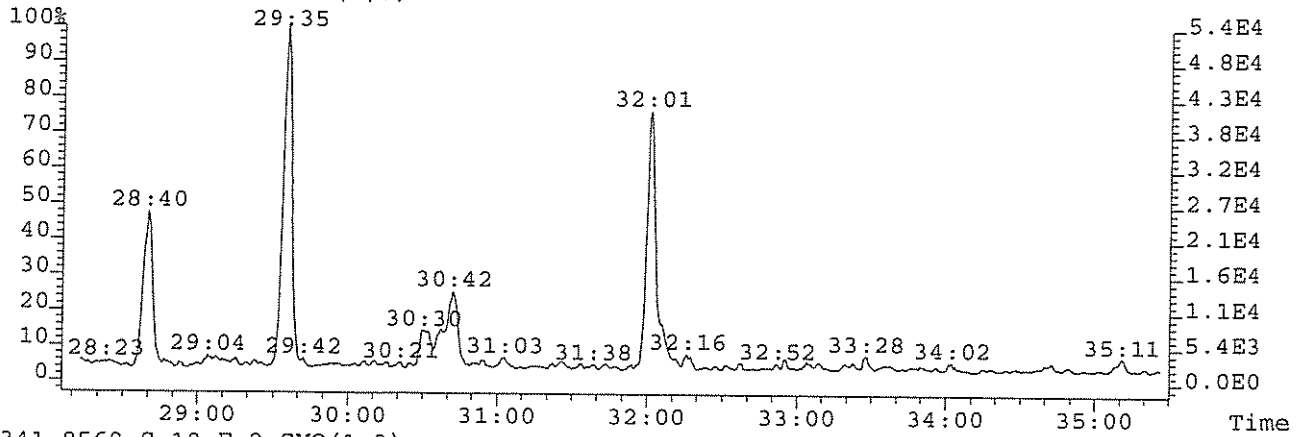
403.8530 S:13 F:2 SMO(1,3)



PCDDsクロマトグラム (6)  
(HxCDDs)

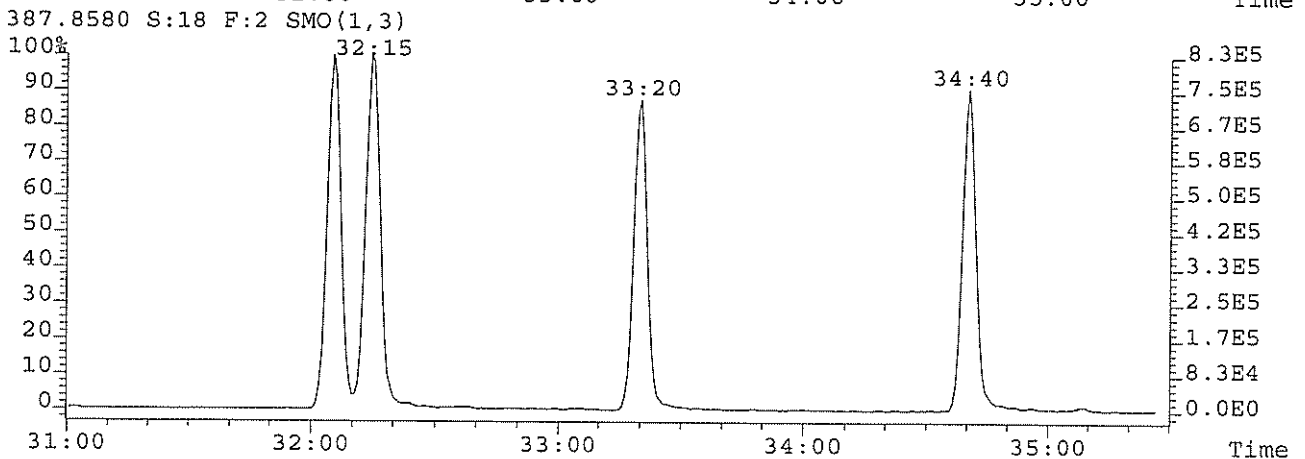
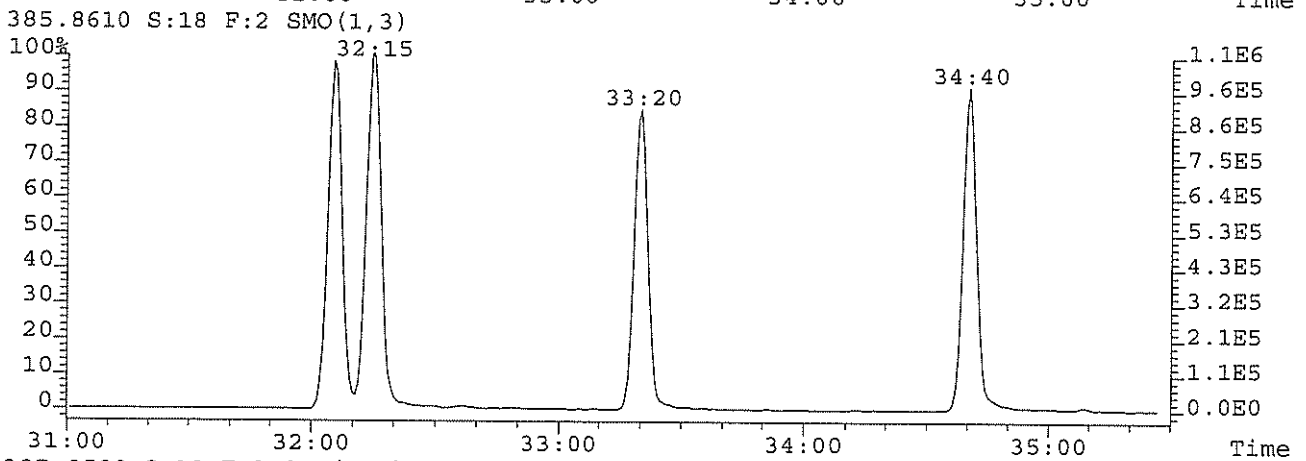
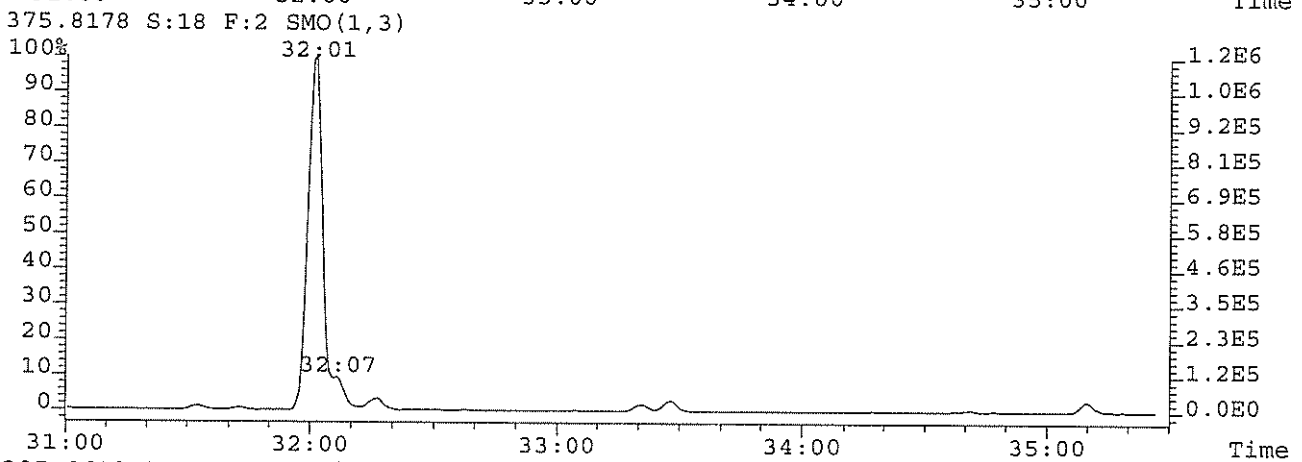
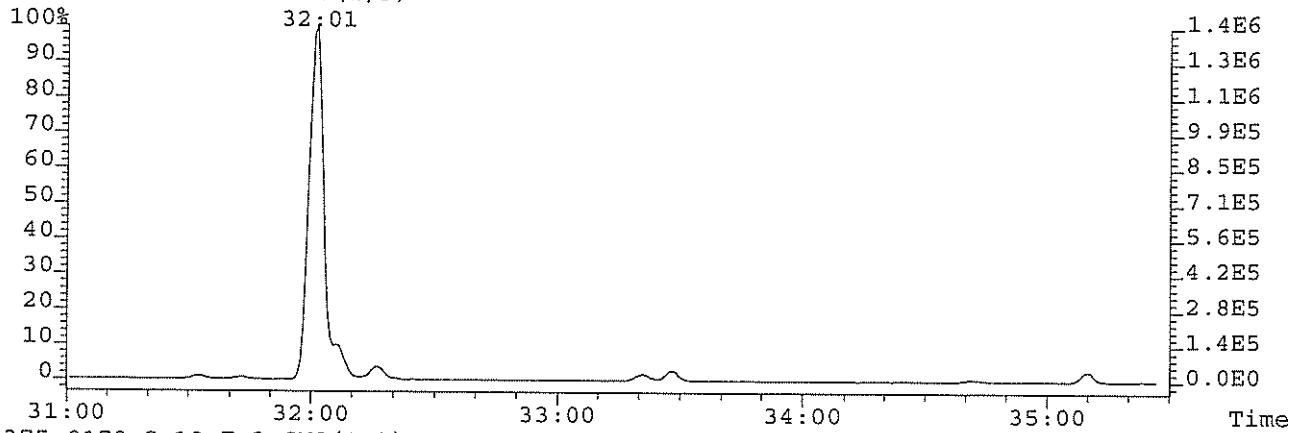


File:130711-2 #1-649 Acq:12-JUL-2013 08:53:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0956 3 Exp:RH-PD22  
339.8597 S:18 F:2 SMO(1,3)



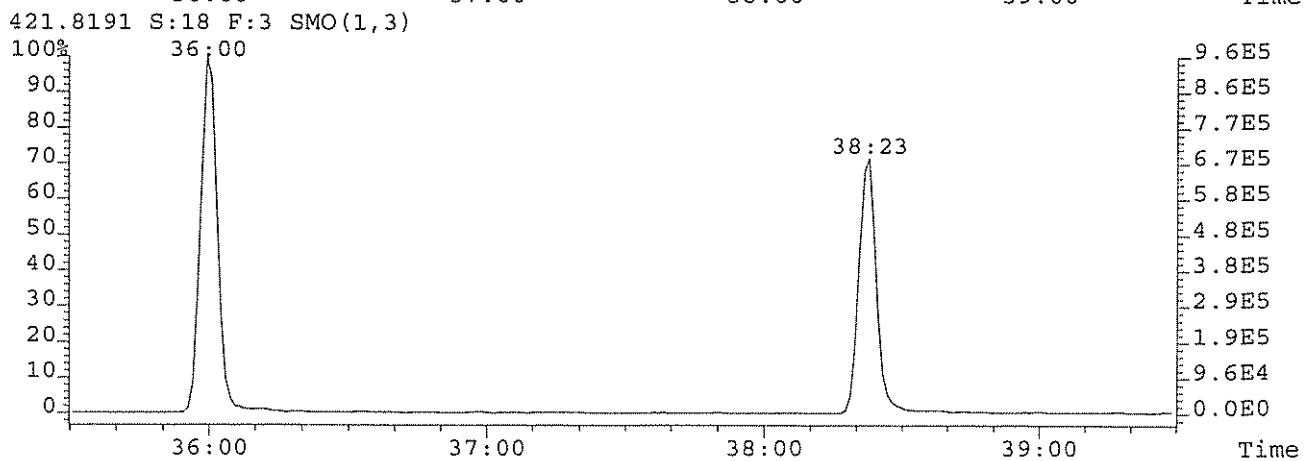
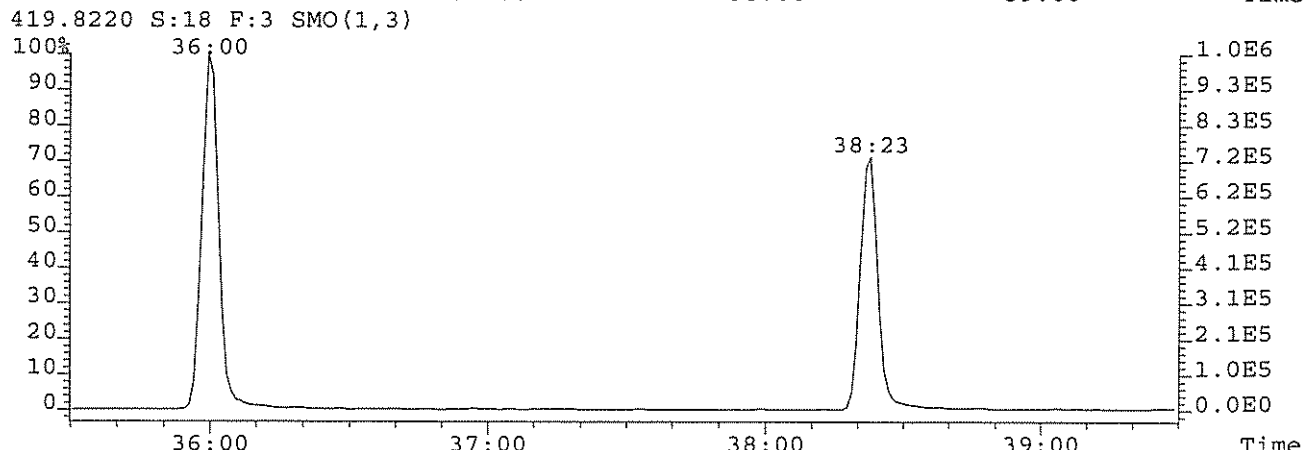
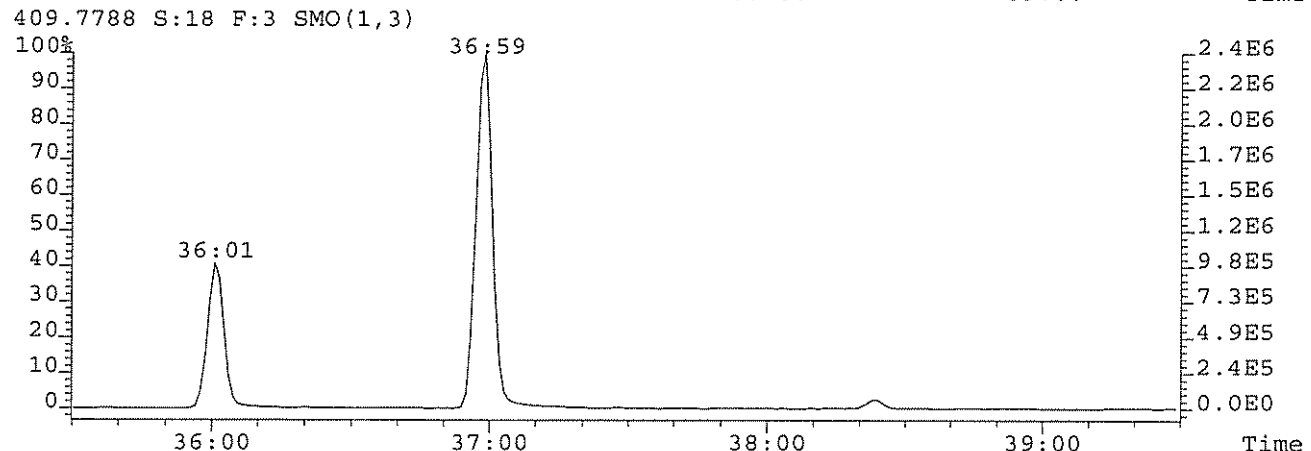
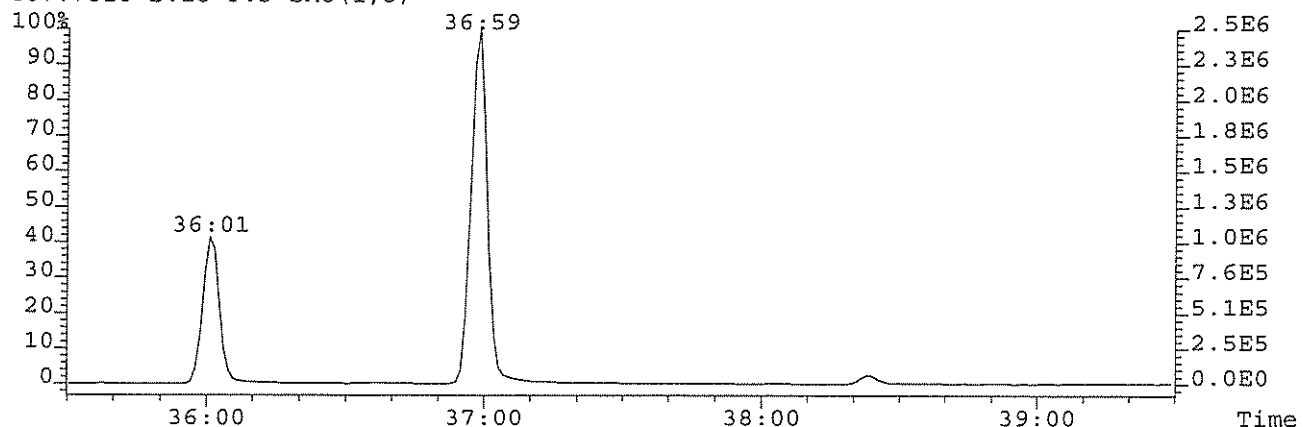
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130711-2 #1-649 Acq:12-JUL-2013 08:53:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0956 3 Exp:RH-PD22  
373.8207 S:18 F:2 SMO(1,3)



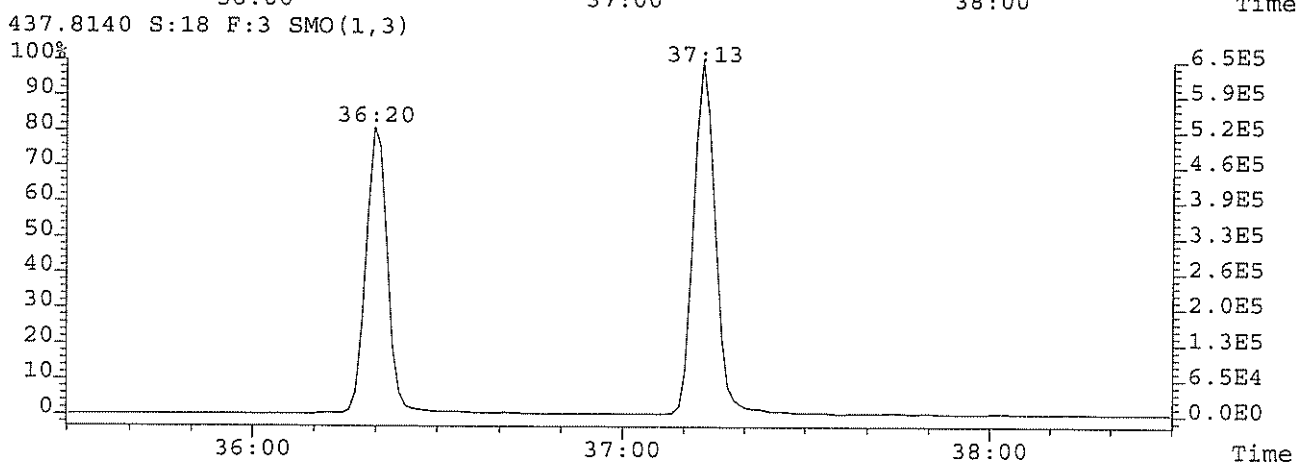
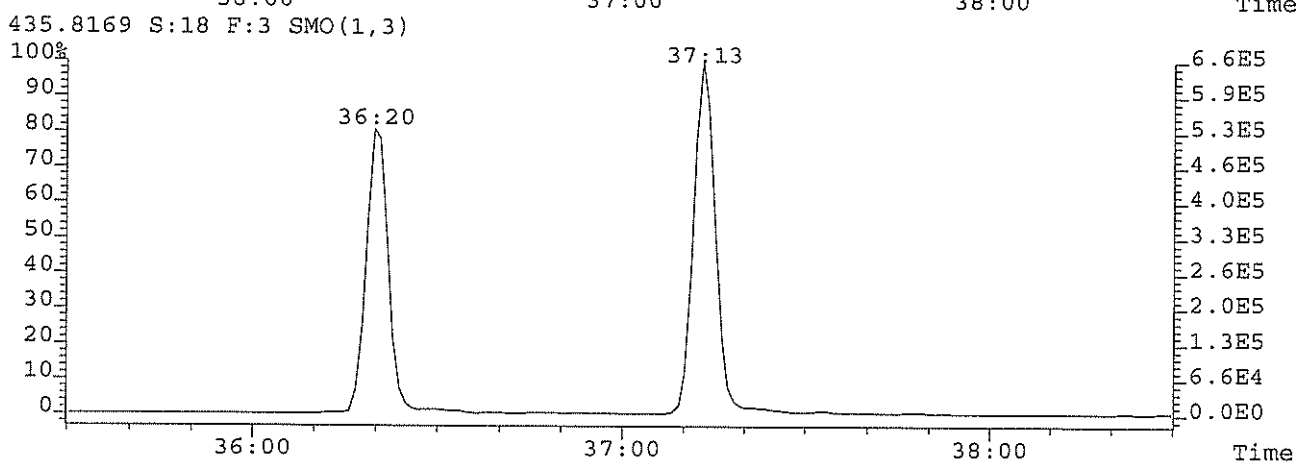
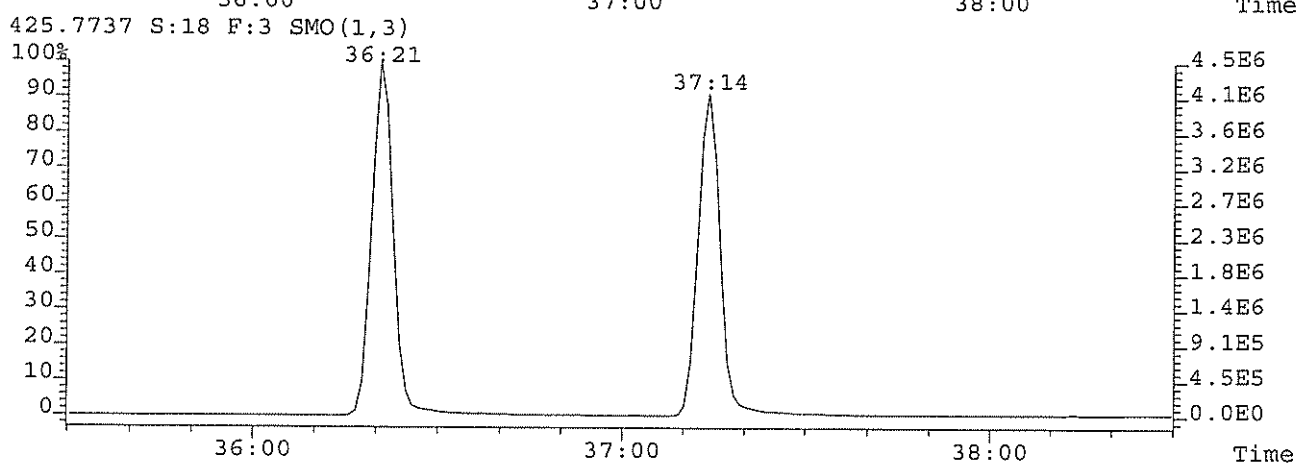
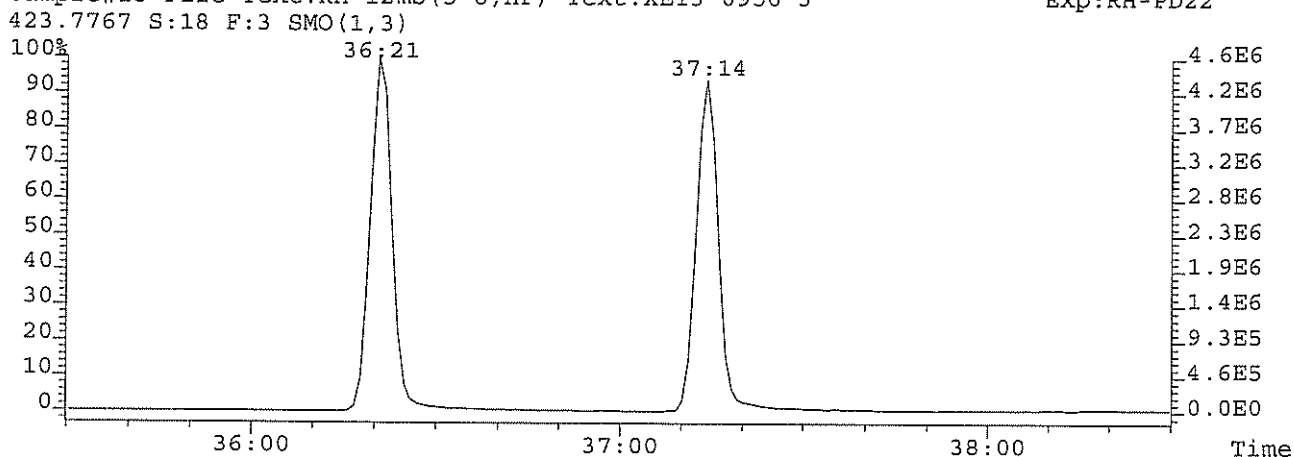
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130711-2 #1-561 Acq:12-JUL-2013 08:53:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0956 3 Exp:RH-PD22  
407.7818 S:18 F:3 SMO(1,3)



PCDFsクロマトグラム (9)  
(HpCDFs)

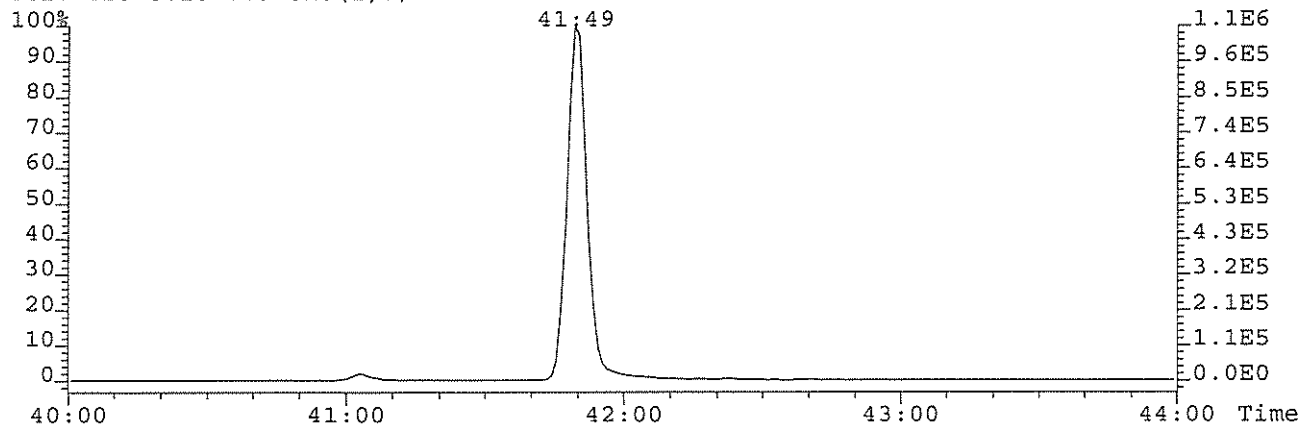
File:130711-2 #1-561 Acq:12-JUL-2013 08:53:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0956 3 Exp:RH-PD22



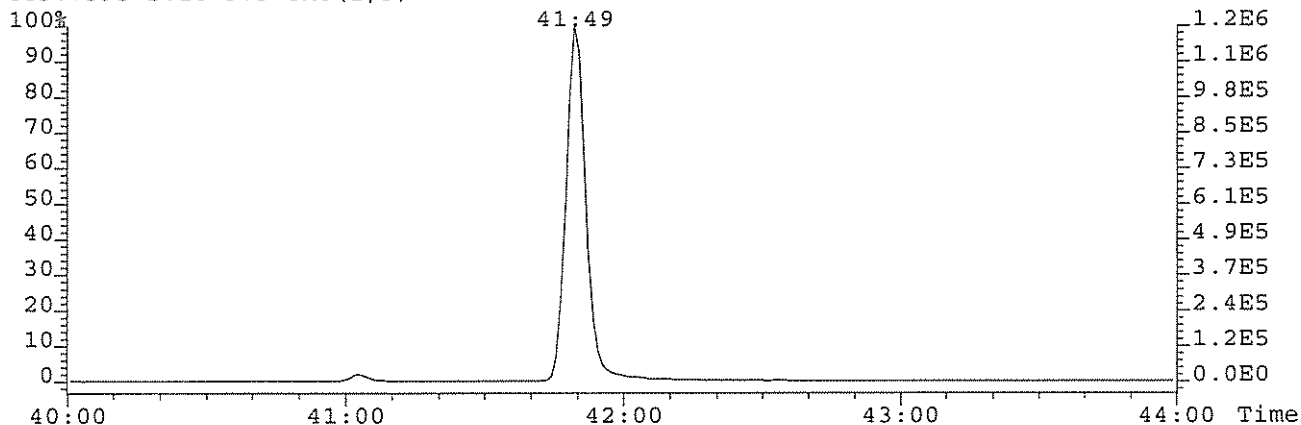
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130711-2 #1-561 Acq:12-JUL-2013 08:53:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0956 3 Exp:RH-PD22

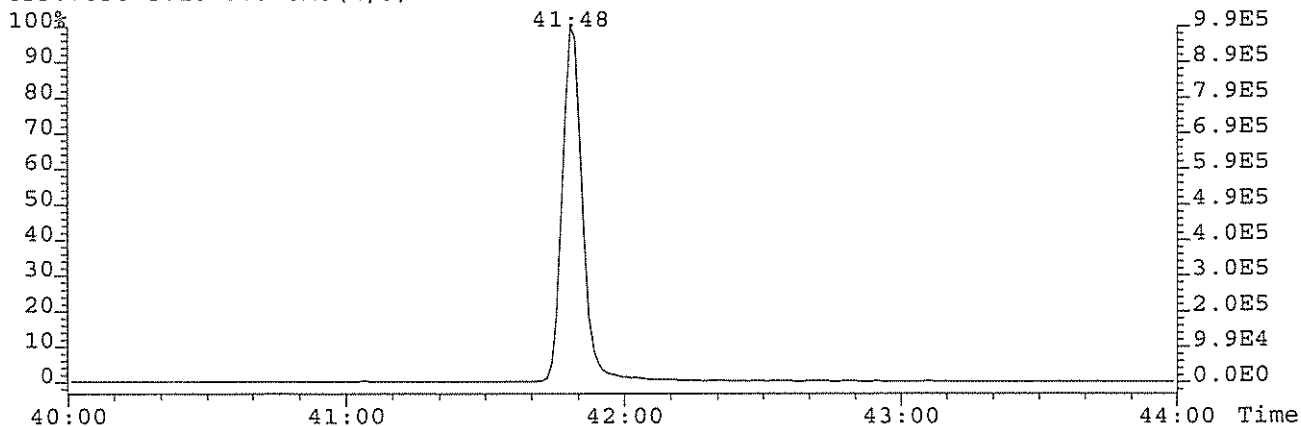
441.7428 S:18 F:3 SMO(1,3)



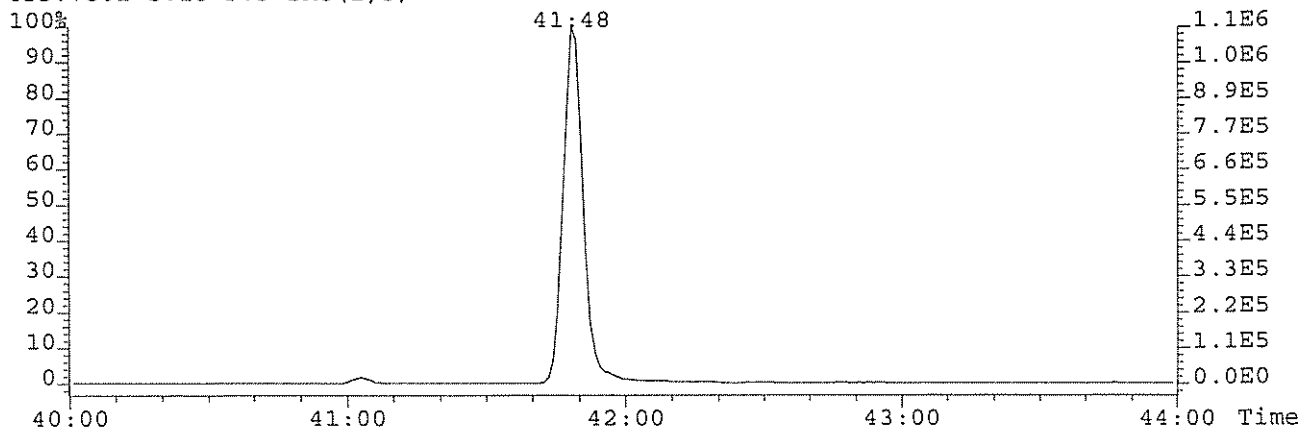
443.7398 S:18 F:3 SMO(1,3)



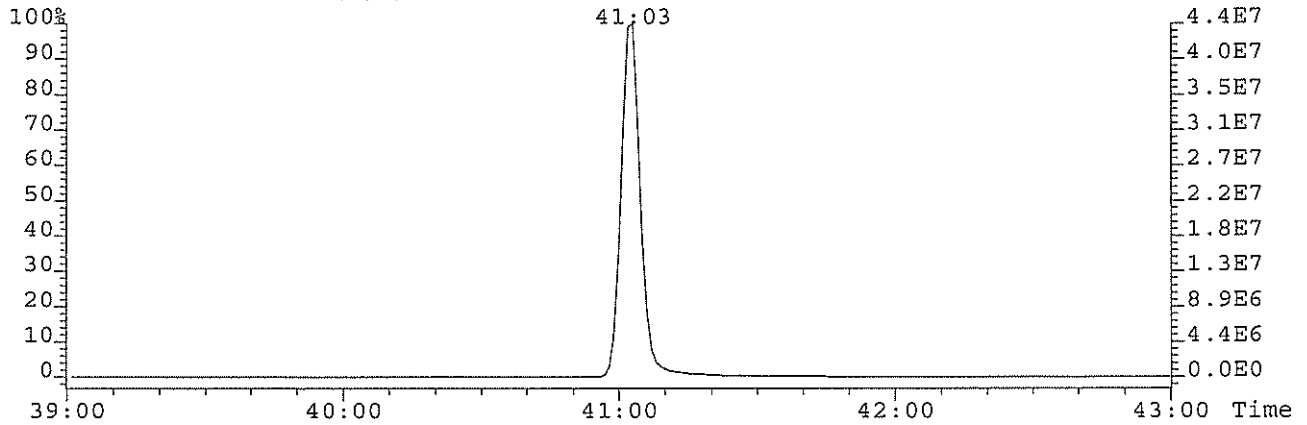
453.7830 S:18 F:3 SMO(1,3)



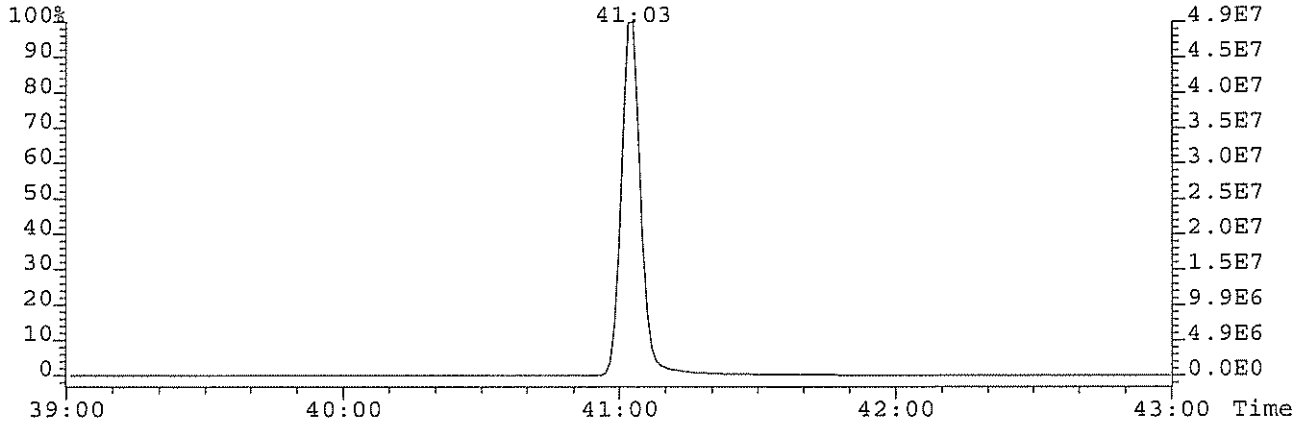
455.7801 S:18 F:3 SMO(1,3)



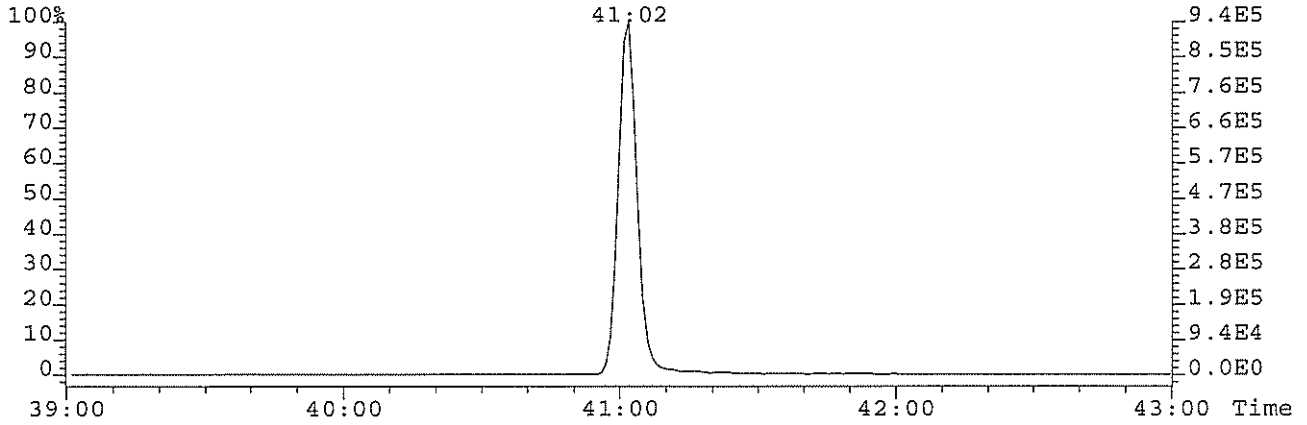
File:130711-2 #1-561 Acq:12-JUL-2013 08:53:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0956 3 Exp:RH-PD22  
457.7377 S:18 F:3 SMO(1,3)



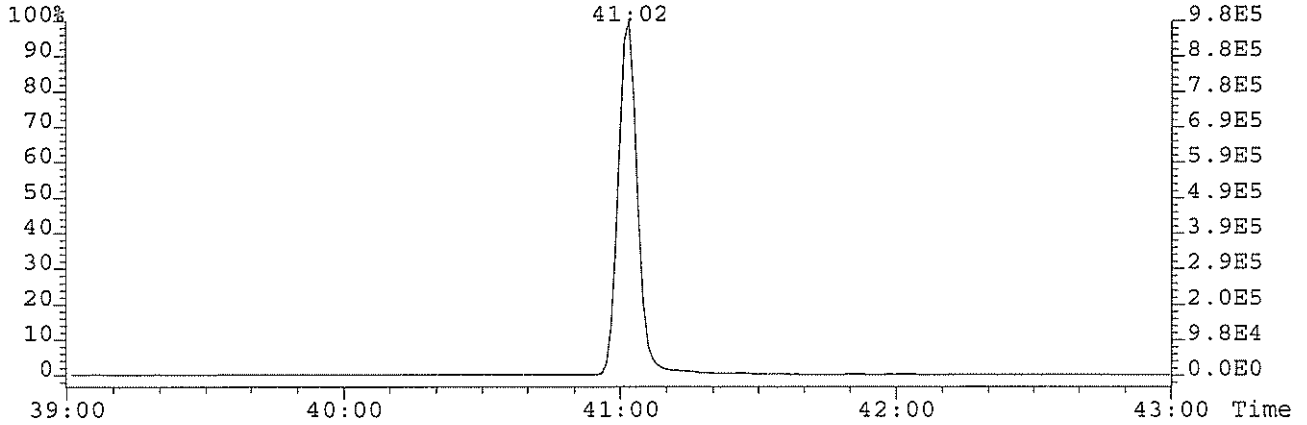
459.7348 S:18 F:3 SMO(1,3)



469.7780 S:18 F:3 SMO(1,3)



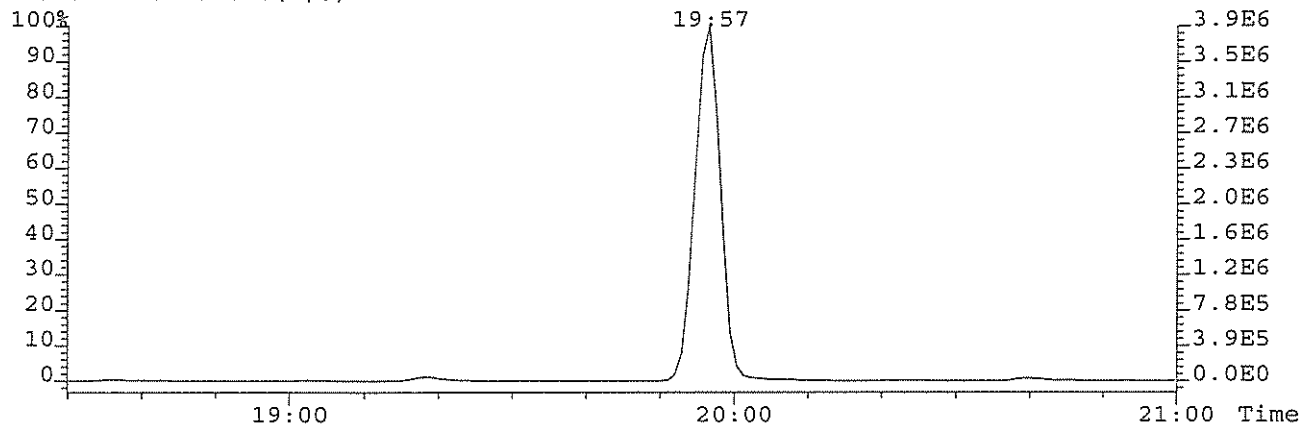
471.7750 S:18 F:3 SMO(1,3)



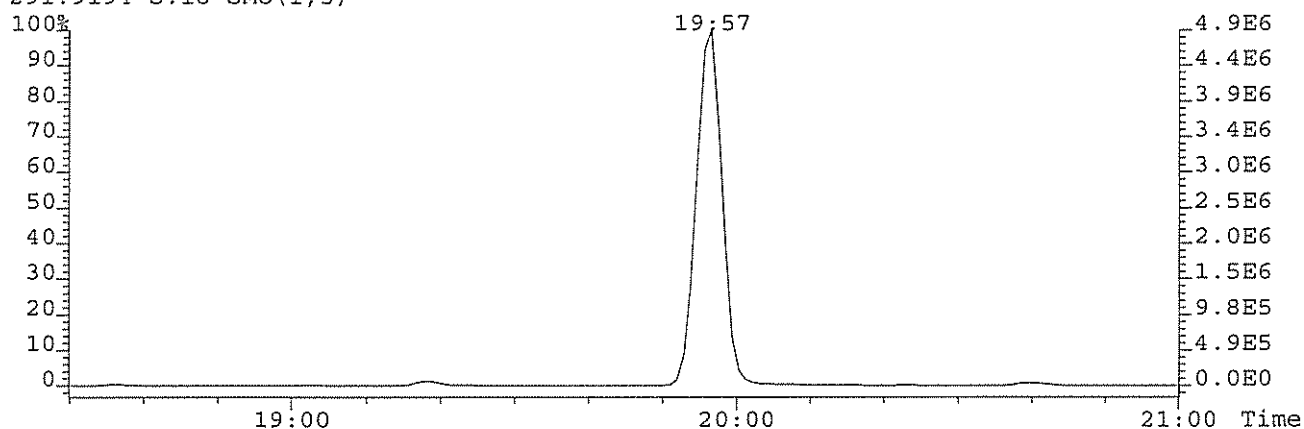
PCDDsクロマトグラム (12)  
(OCDD)

File:130711-2 #1-1430 Acq:12-JUL-2013 08:53:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0956 3 Exp:RH-PD22

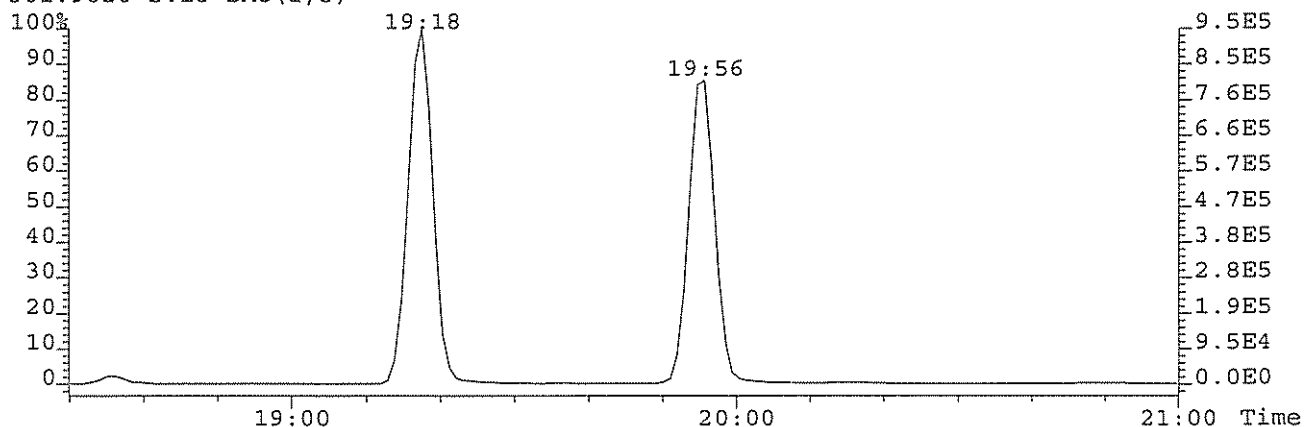
289.9224 S:18 SMO(1,3)



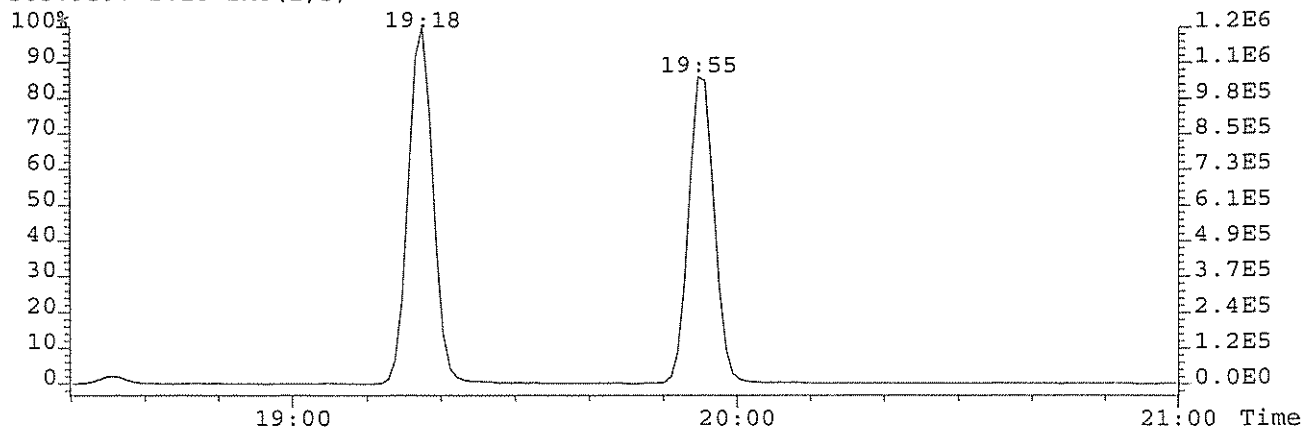
291.9194 S:18 SMO(1,3)



301.9626 S:18 SMO(1,3)

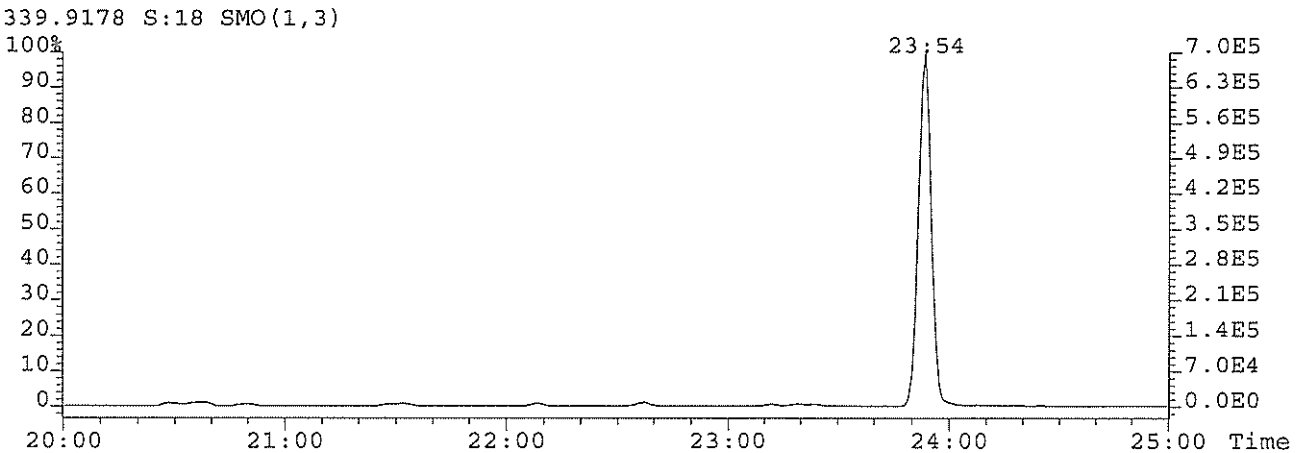
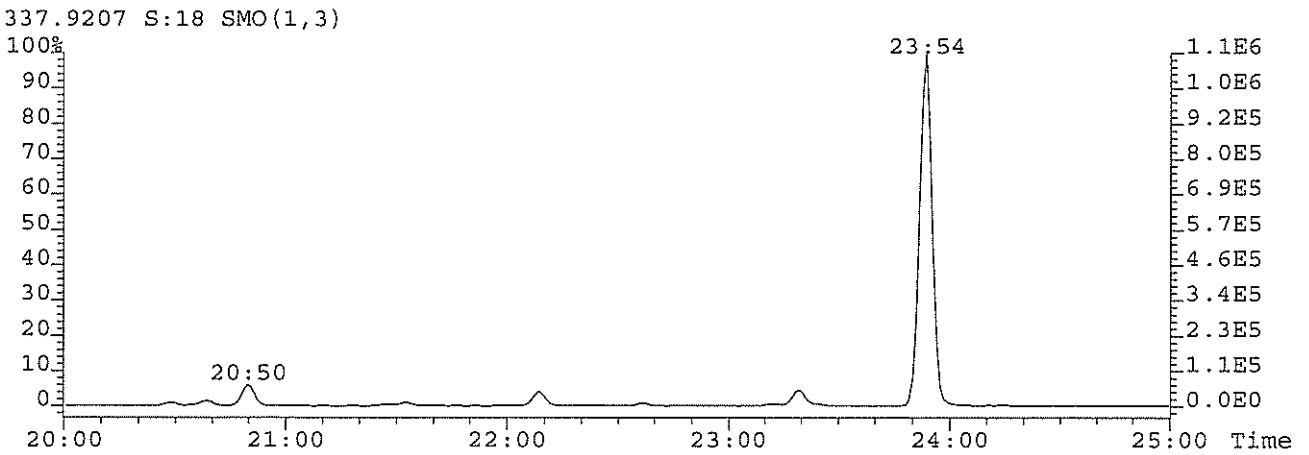
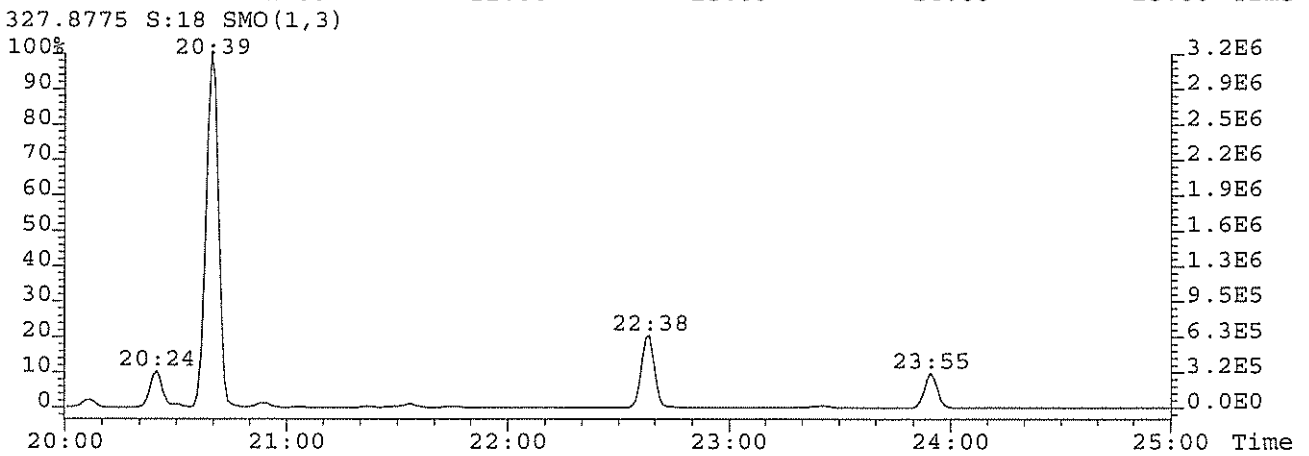
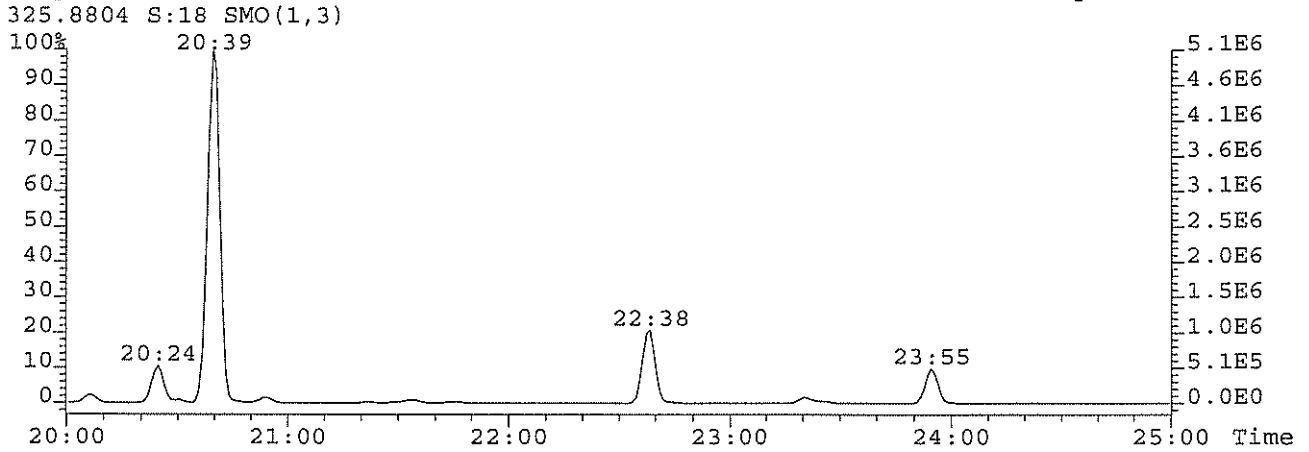


303.9597 S:18 SMO(1,3)



DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 08:53:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0956 3 Exp:RH-PD22

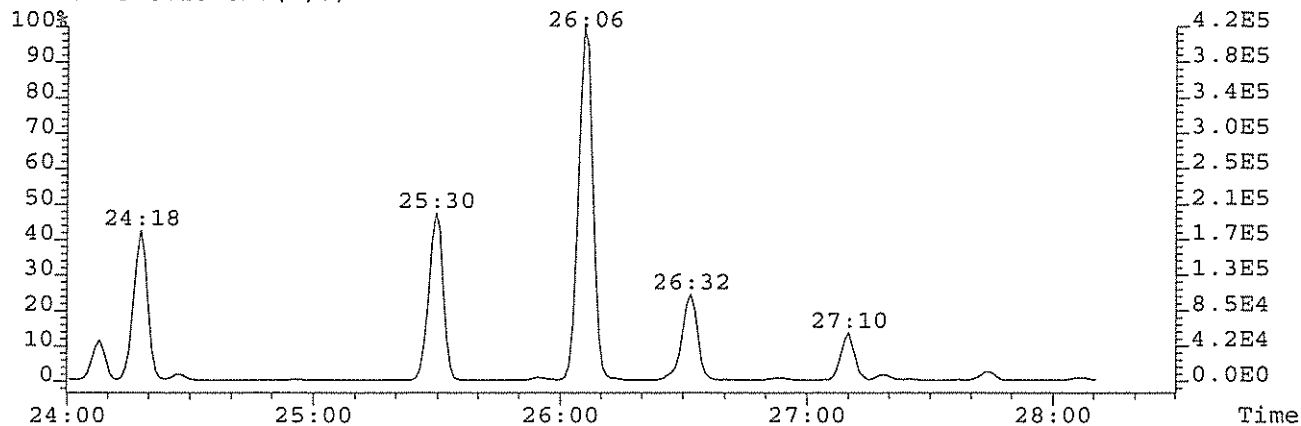


DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

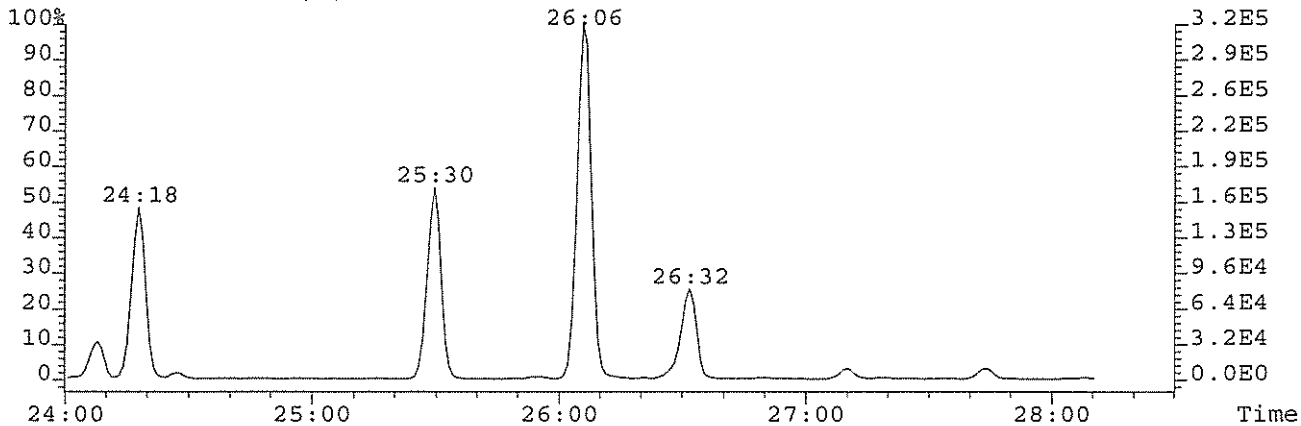


File:130711-2 #1-1430 Acq:12-JUL-2013 08:53:56 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0956 3 Exp:RH-PD22

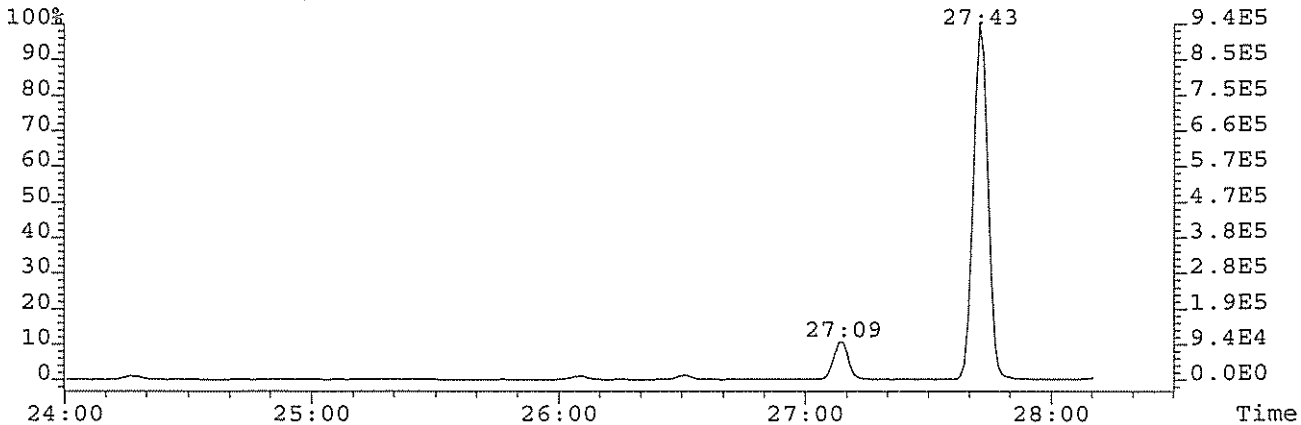
359.8415 S:18 SMO(1,3)



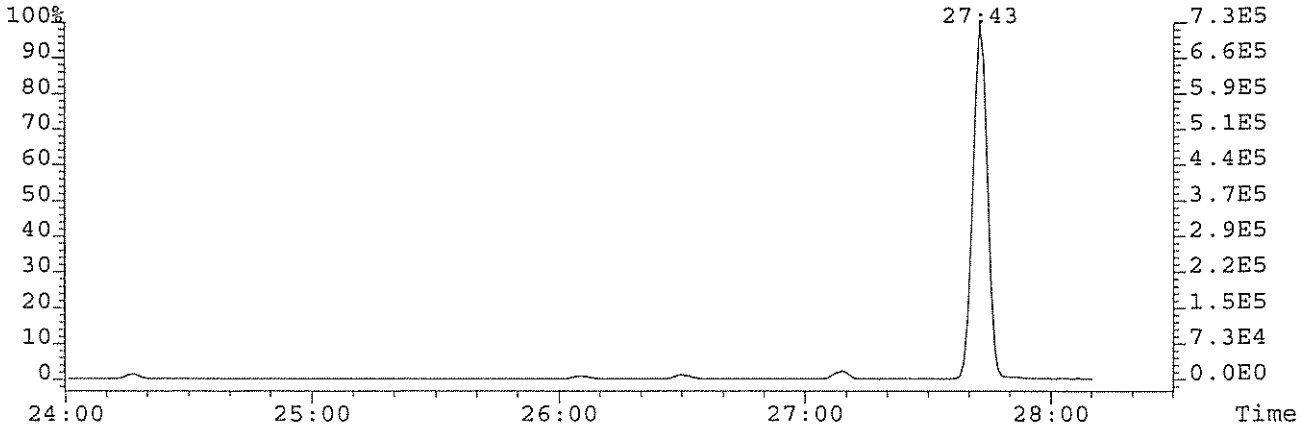
361.8385 S:18 SMO(1,3)



371.8817 S:18 SMO(1,3)

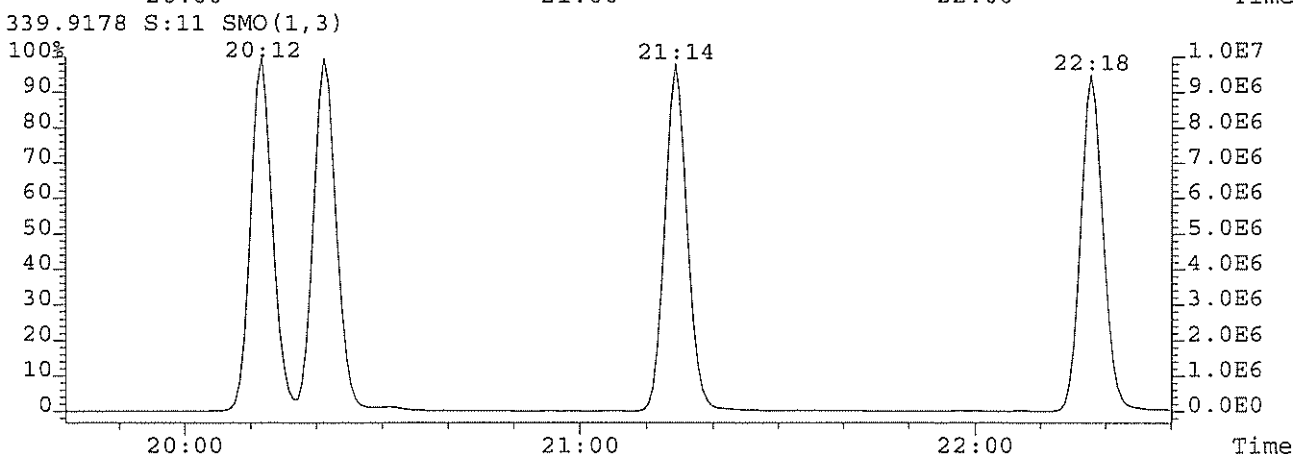
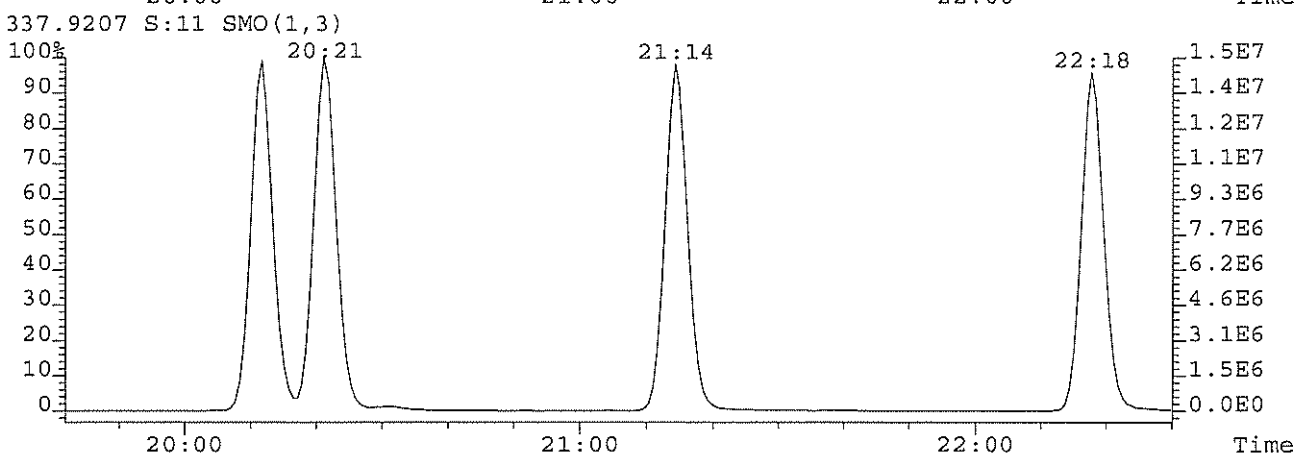
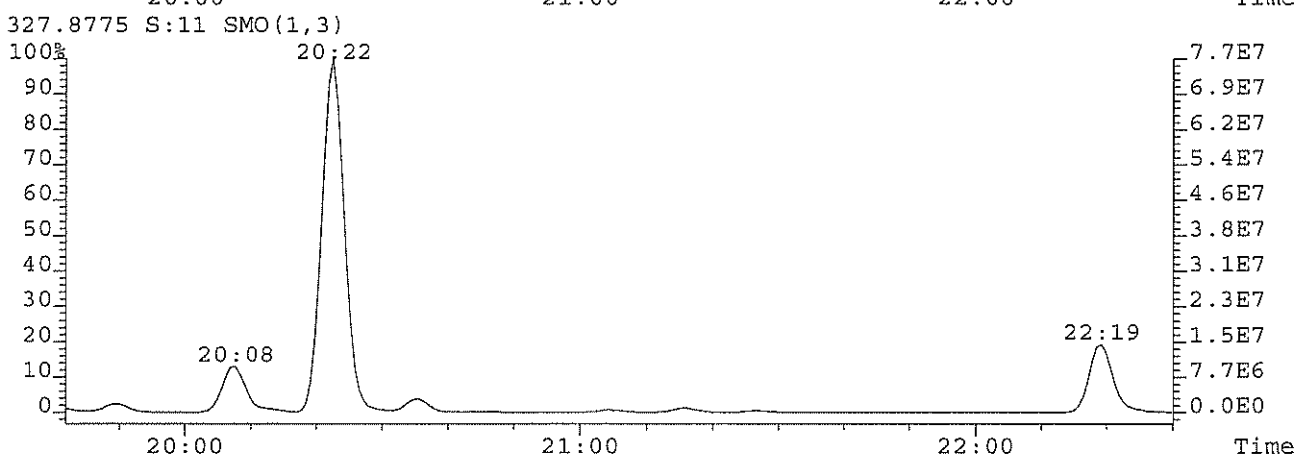
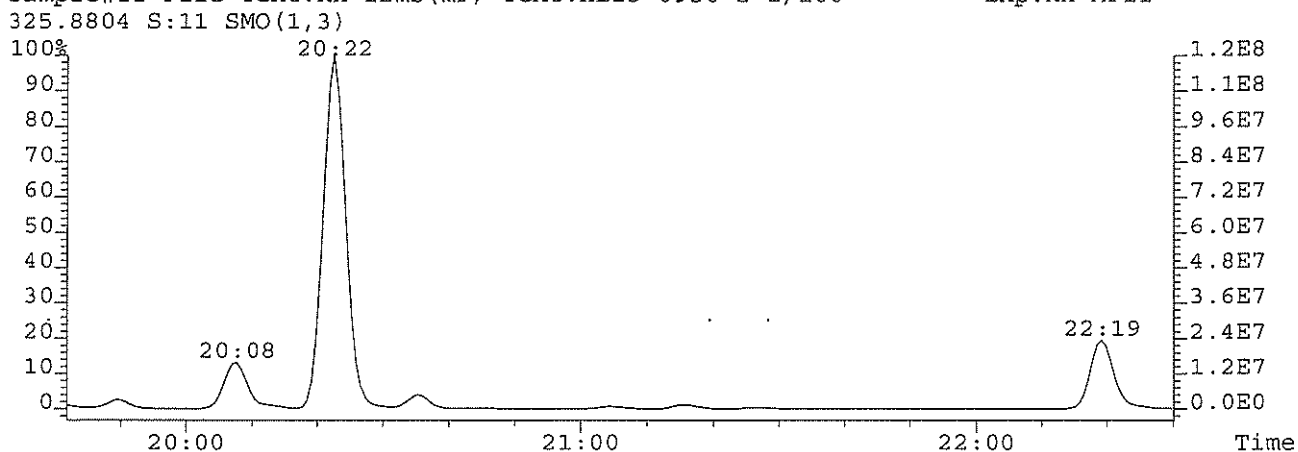


373.8788 S:18 SMO(1,3)



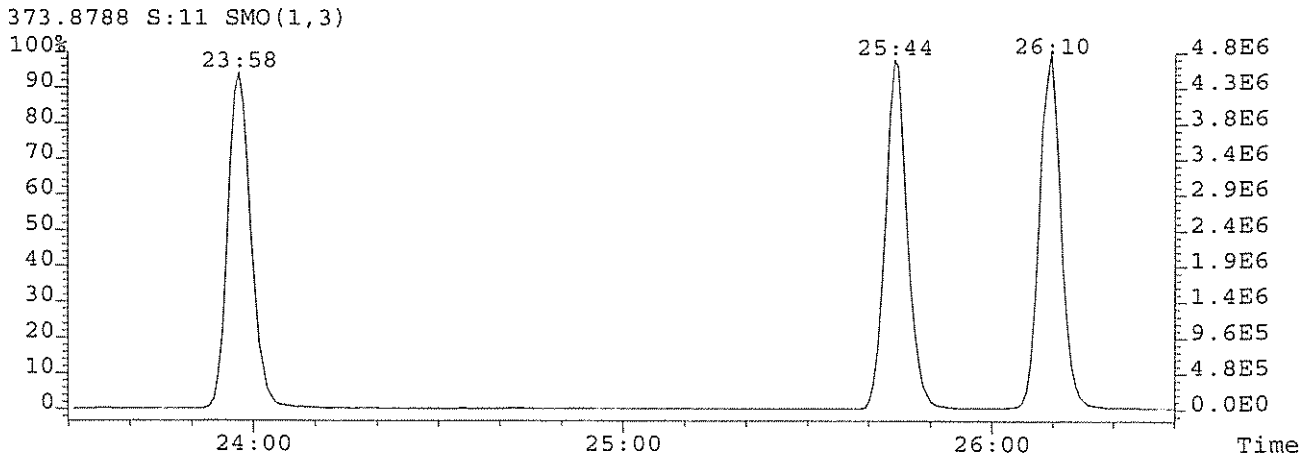
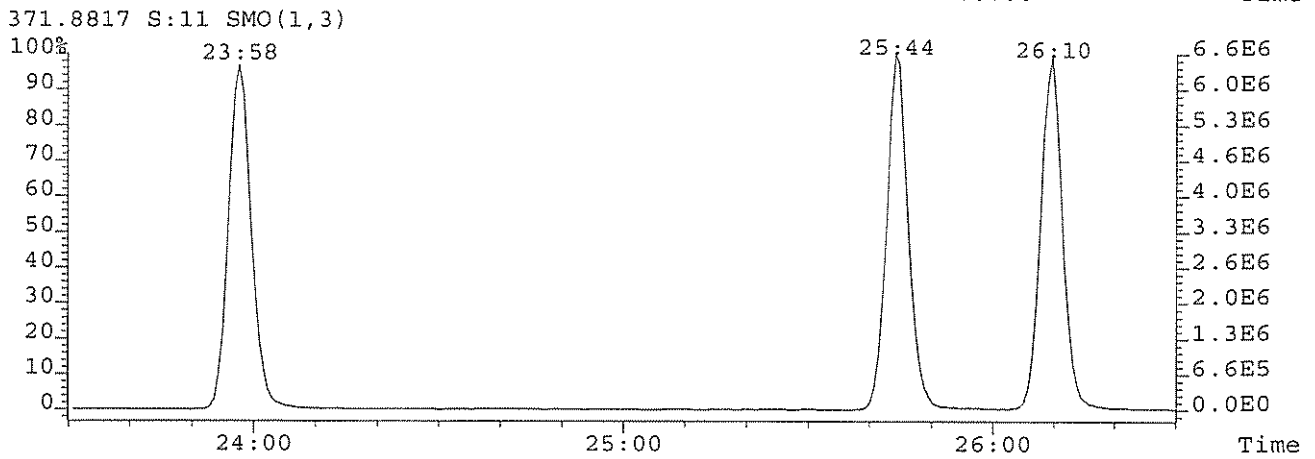
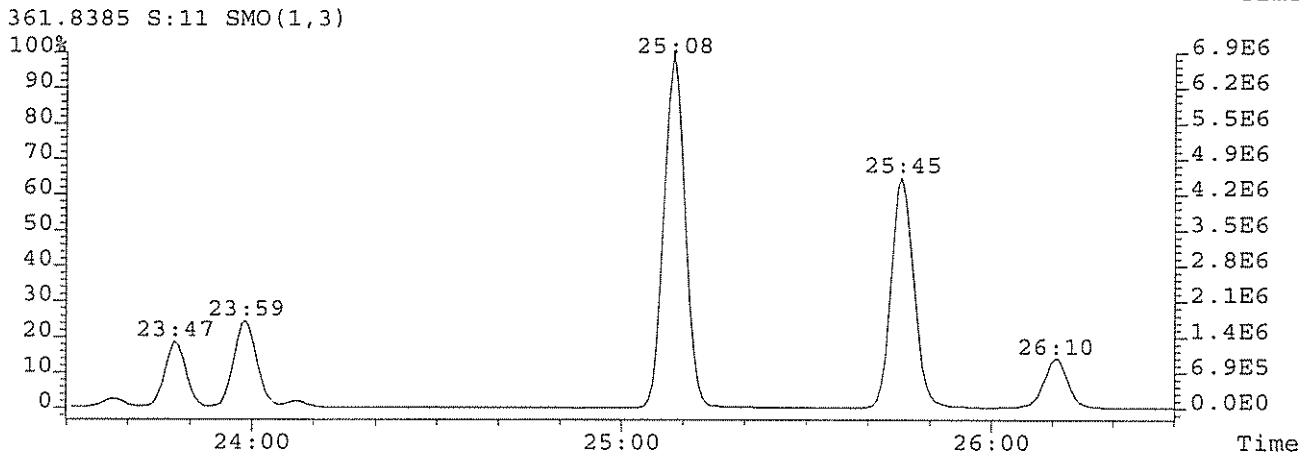
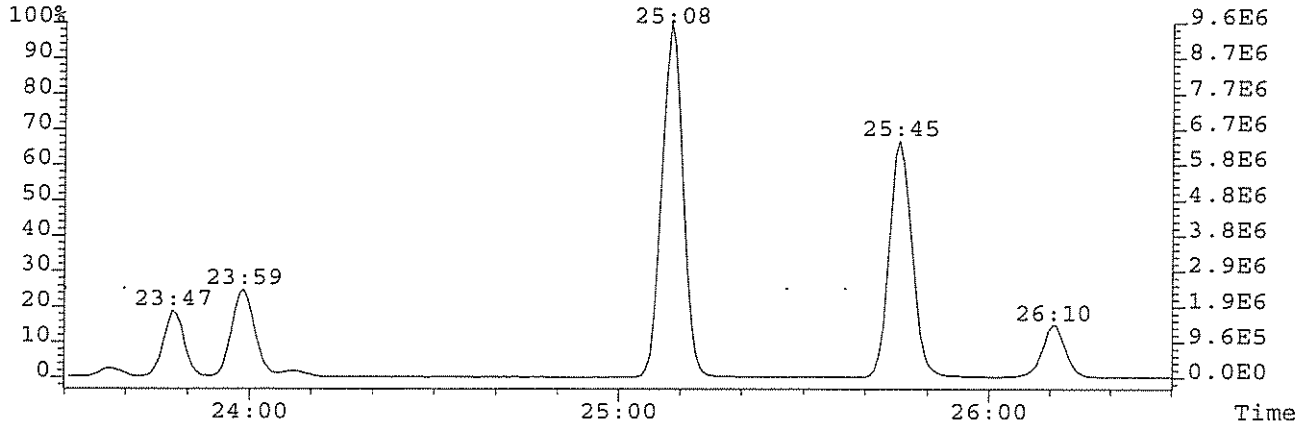
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130713 #1-2899 Acq:13-JUL-2013 18:51:59 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(mP) Text:XE13 0956 2 1/100 Exp:RH-MP11



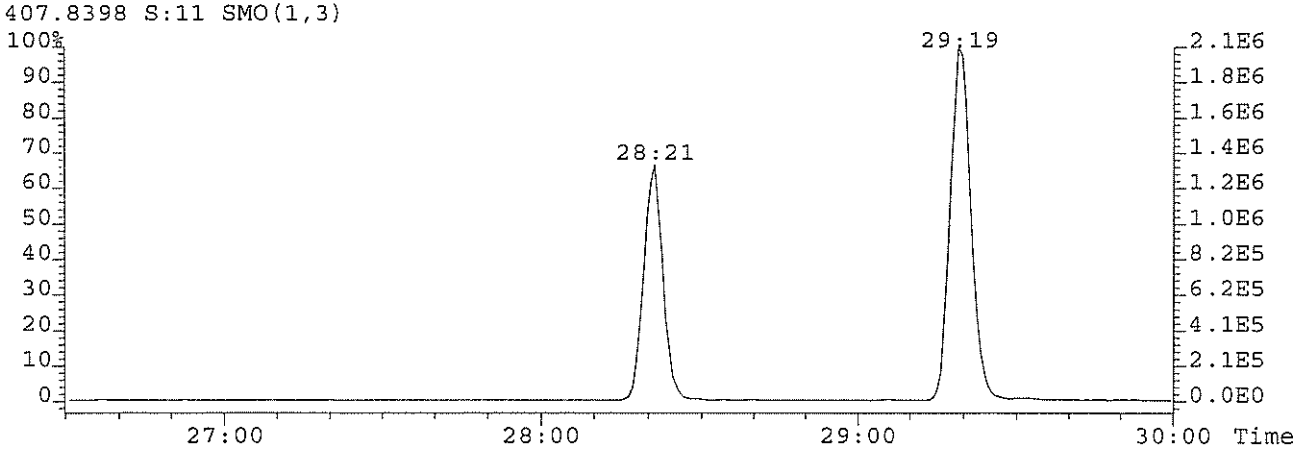
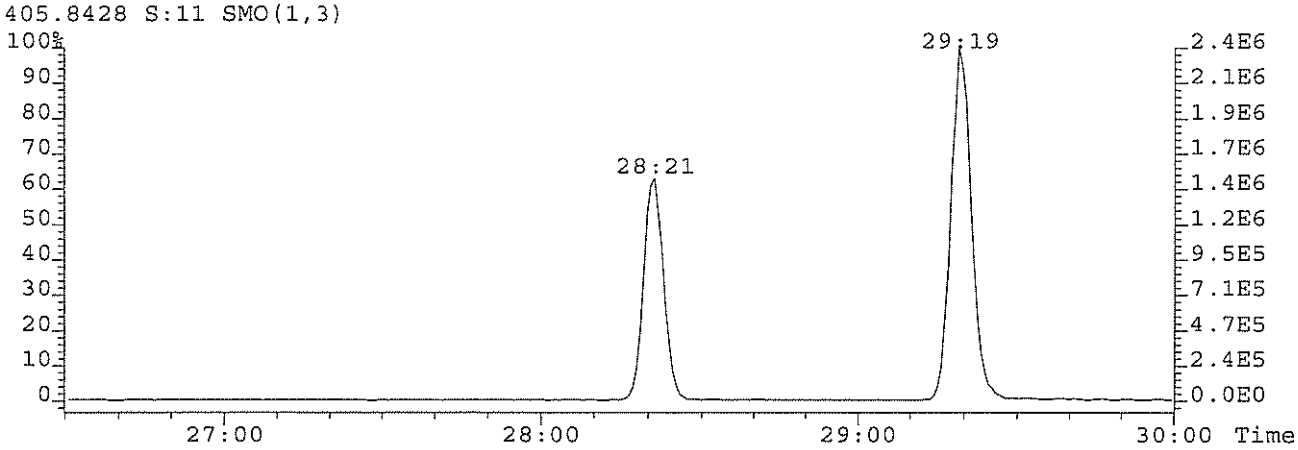
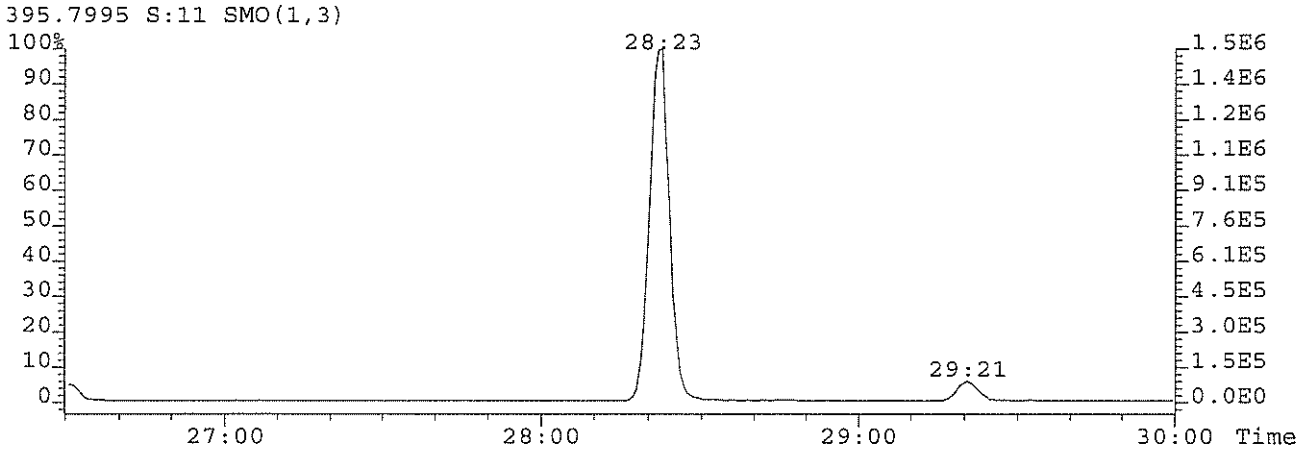
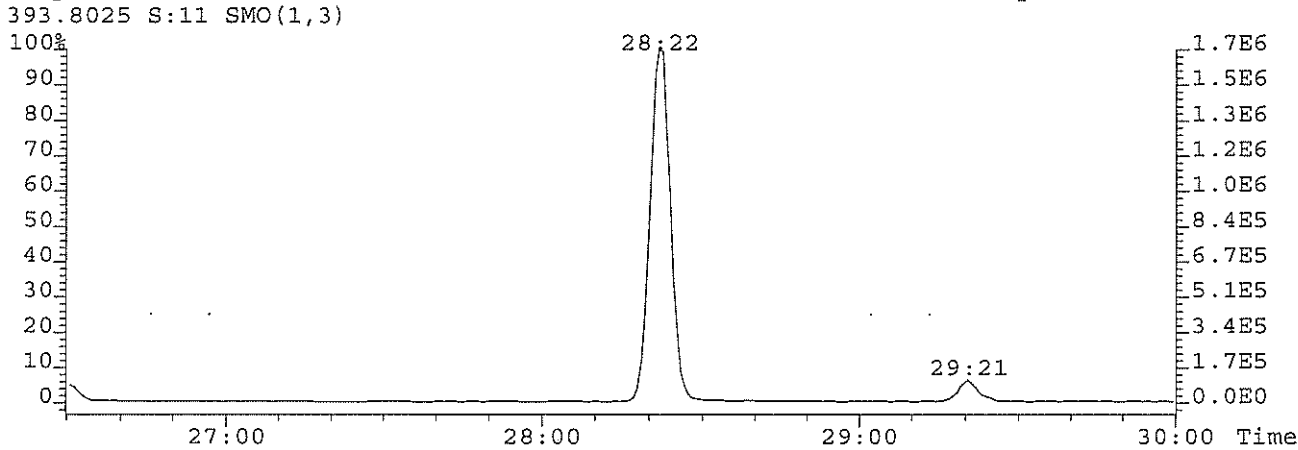
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130713 #1-2899 Acq:13-JUL-2013 18:51:59 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(mP) Text:XE13 0956 2 1/100 Exp:RH-MP11  
359.8415 S:11 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

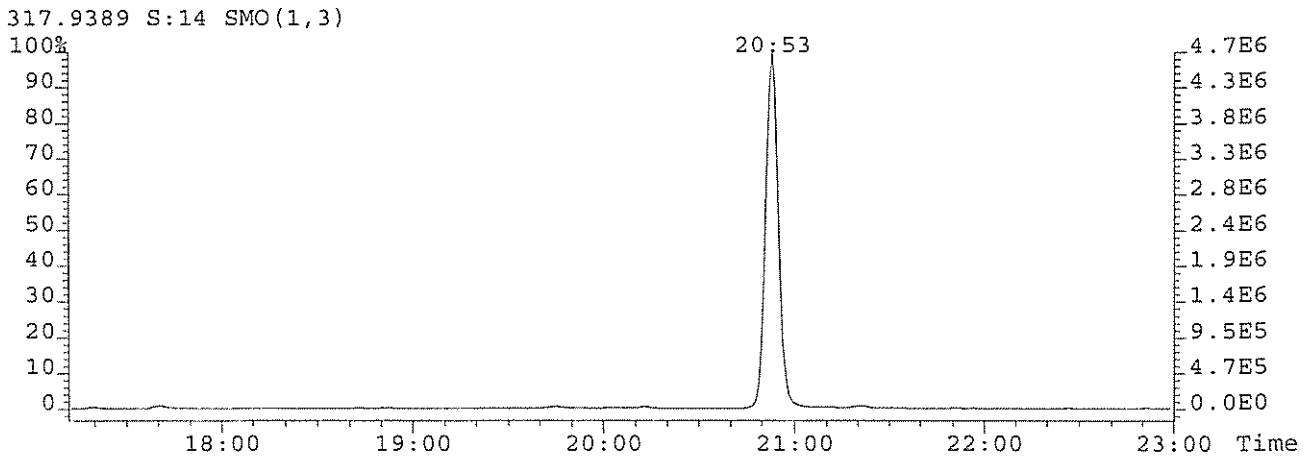
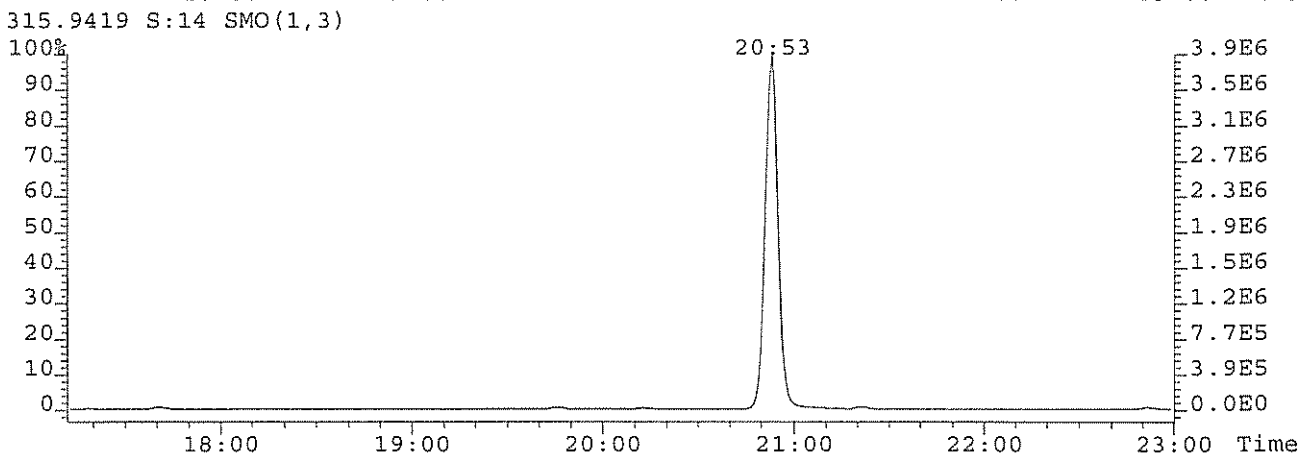
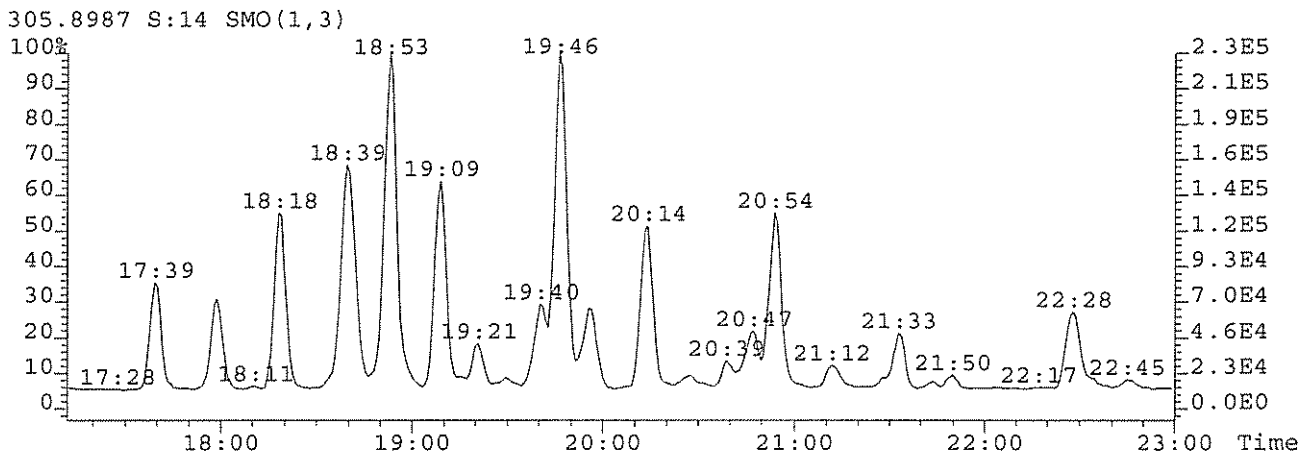
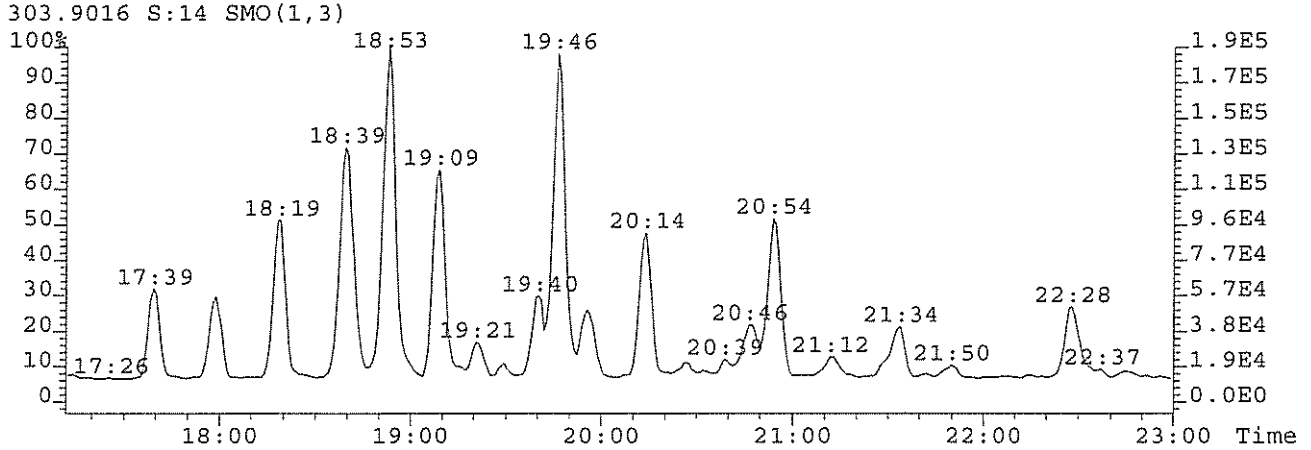
File:130713 #1-2899 Acq:13-JUL-2013 18:51:59 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#11 File Text:RH-12ms(mP) Text:XE13 0956 2 1/100 Exp:RH-MP11



DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

試料管理番号	XE 130957
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.11

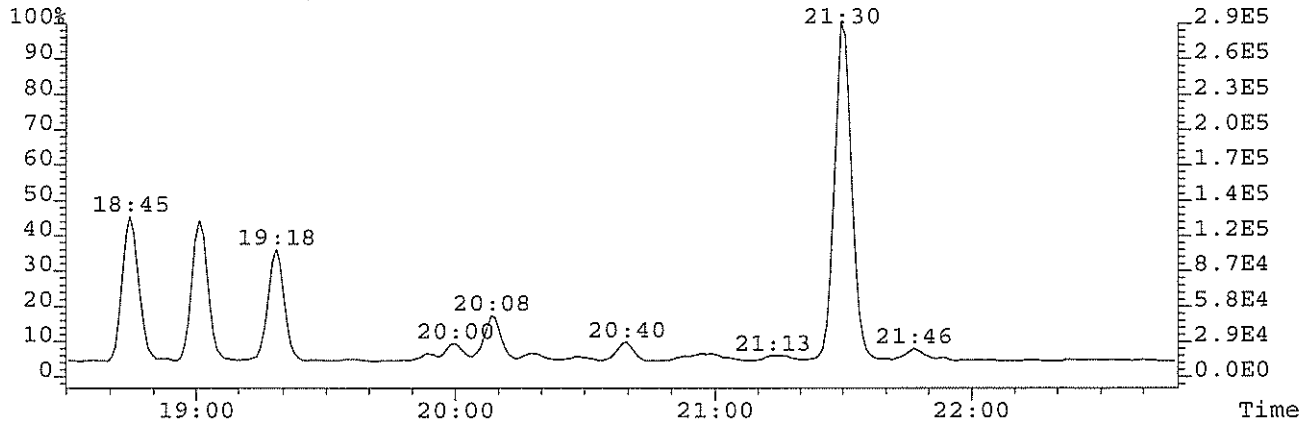
File:130712-2 #1-1578 Acq:13-JUL-2013 02:53:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:BPX-DXN(4-6DXN) Text:XE13 0957 Exp:BPX04



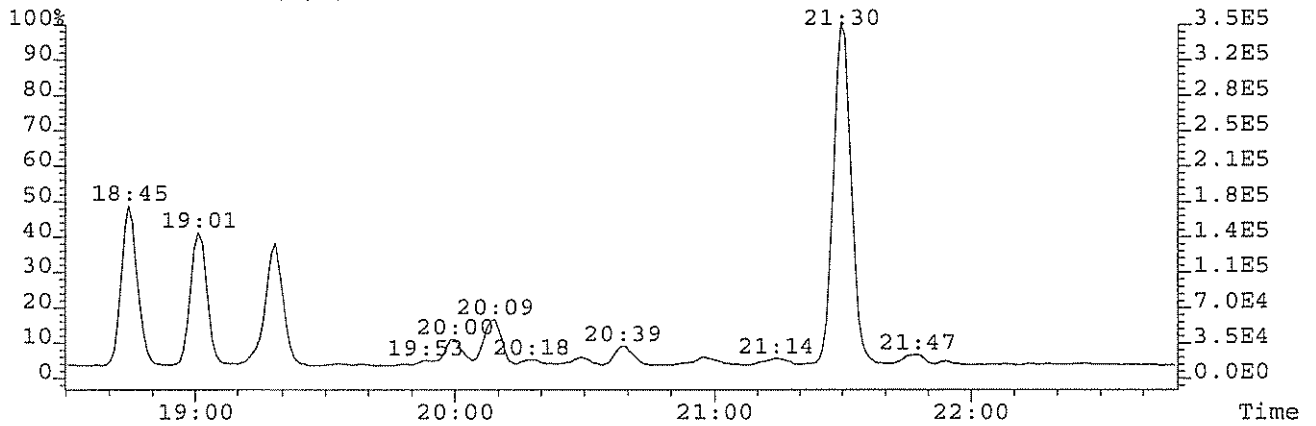
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 02:53:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:BPX-DXN(4-6DXN) Text:XE13 0957 Exp:BPX04

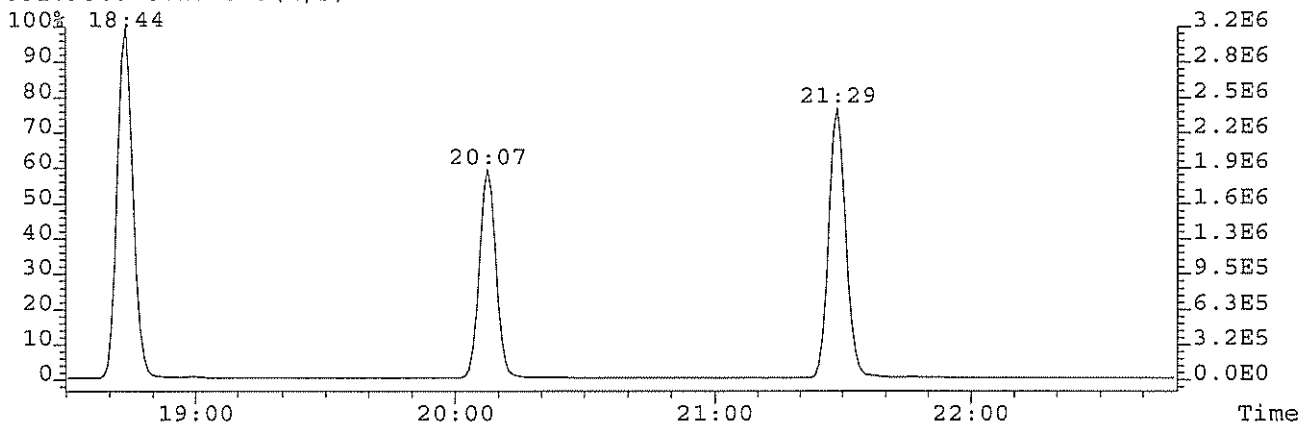
319.8965 S:14 SMO(1,3)



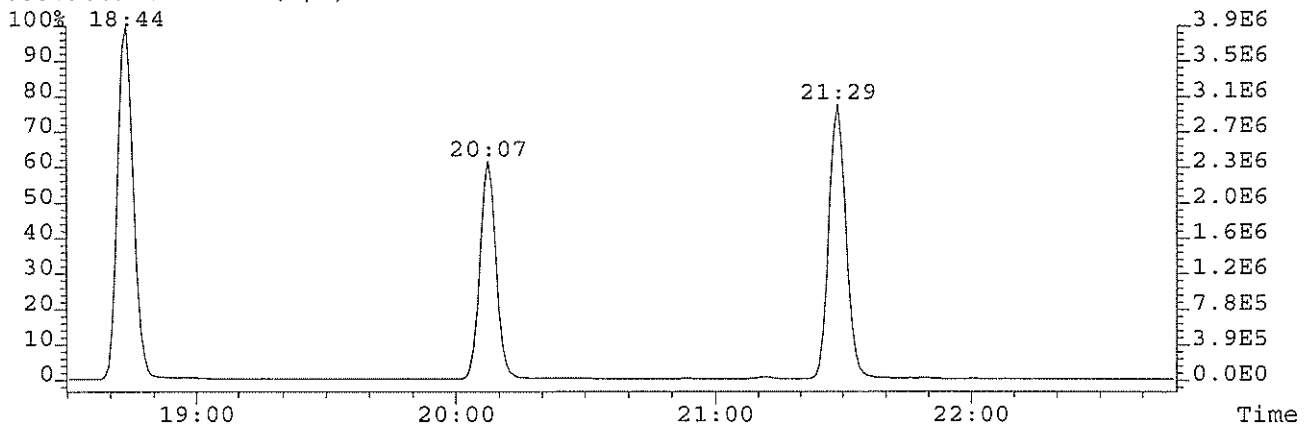
321.8936 S:14 SMO(1,3)



331.9368 S:14 SMO(1,3)

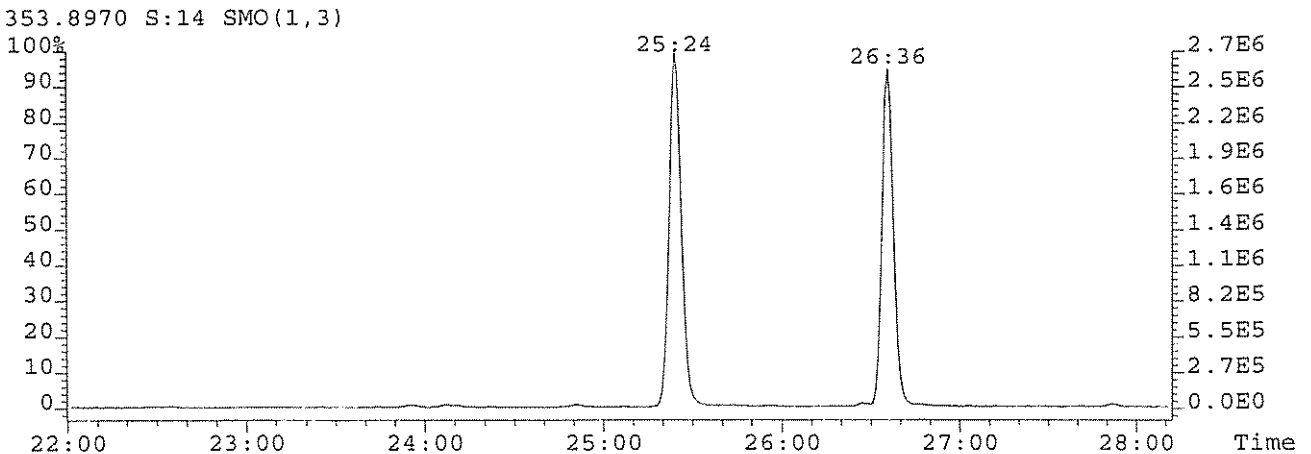
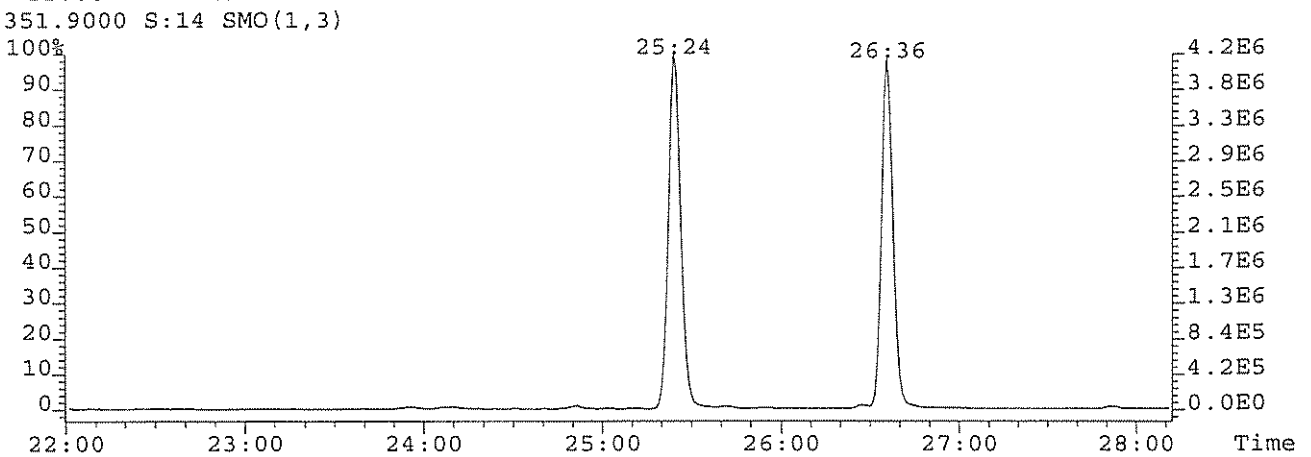
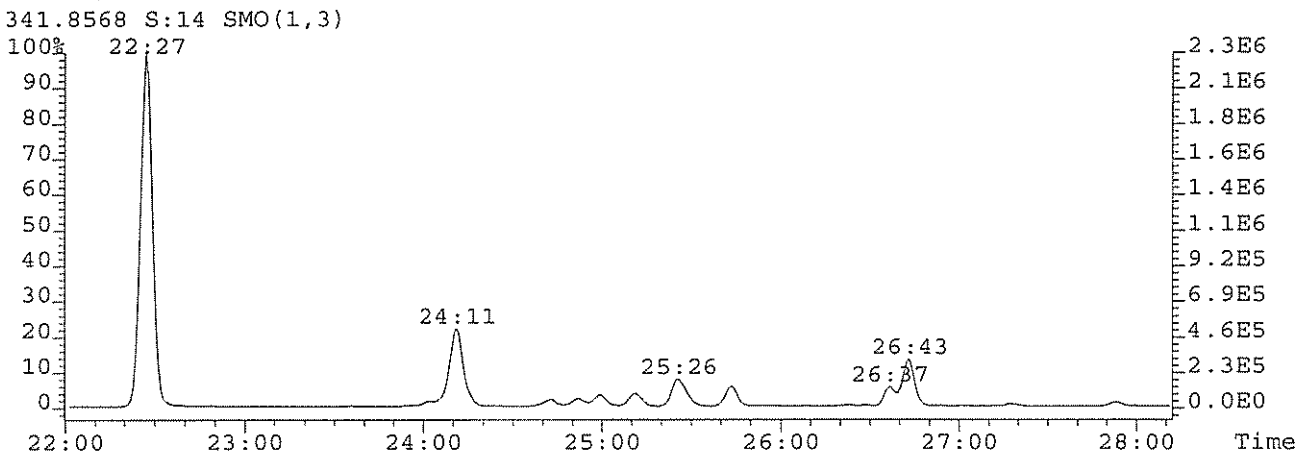
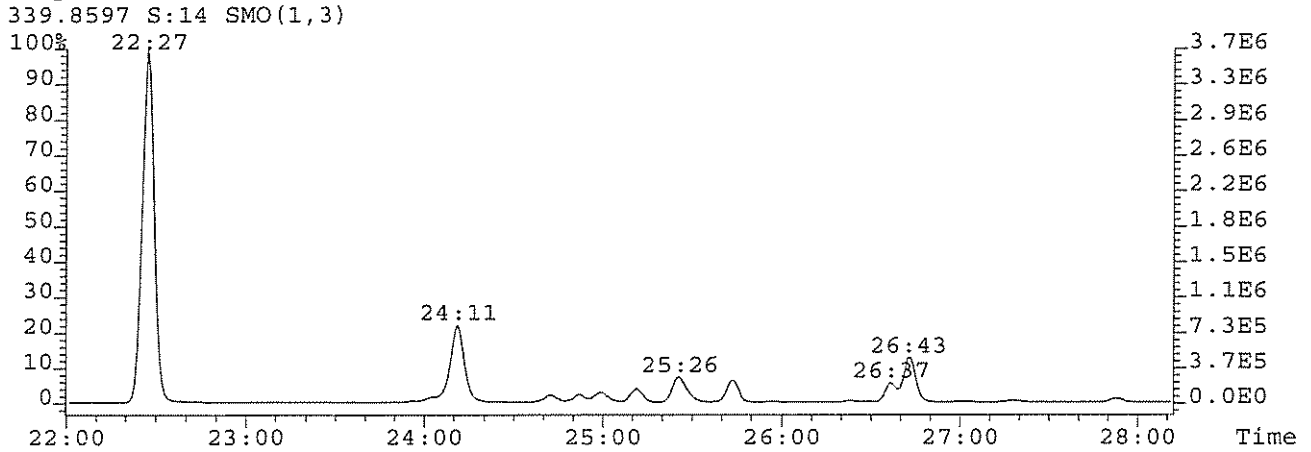


333.9339 S:14 SMO(1,3)



PCDDsクロマトグラム (2)  
(TeCDDs)

File:130712-2 #1-1578 Acq:13-JUL-2013 02:53:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:BPX-DXN(4-6DXN) Text:XE13 0957 Exp:BPX04

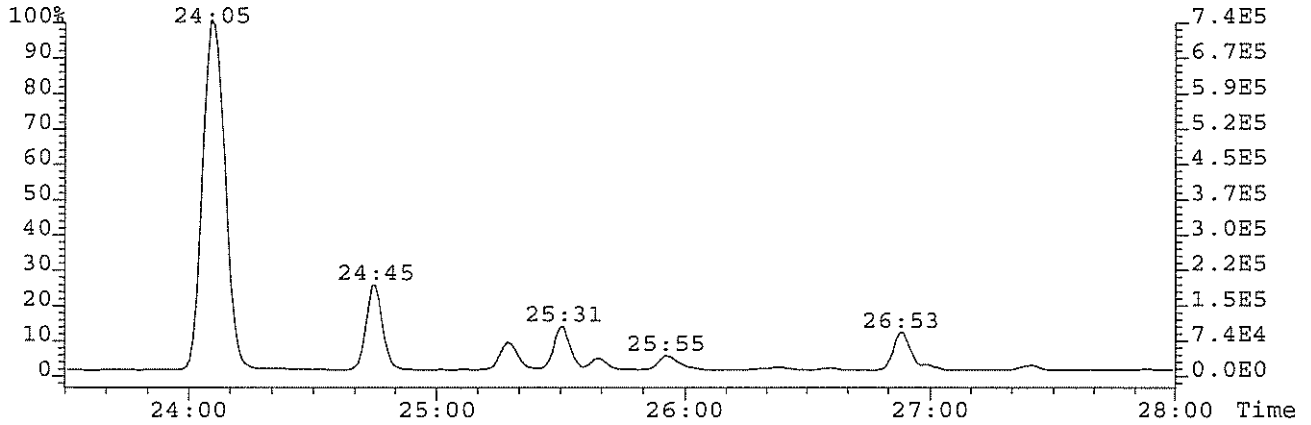


PCDFsクロマトグラム (3)  
(PeCDFs)

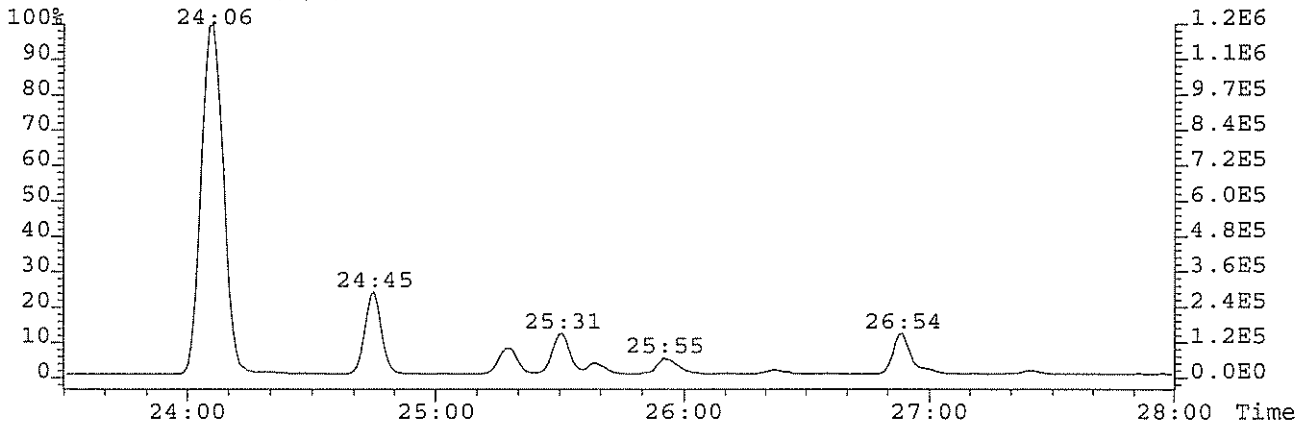


File:130712-2 #1-1578 Acq:13-JUL-2013 02:53:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:BPX-DXN(4-6DXN) Text:XE13 0957 Exp:BPX04

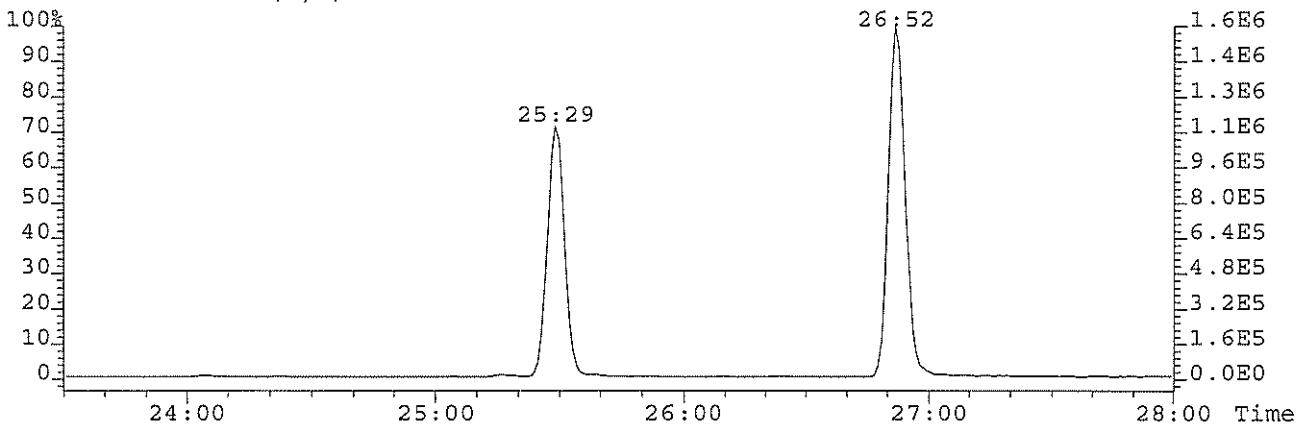
353.8576 S:14 SMO(1,3)



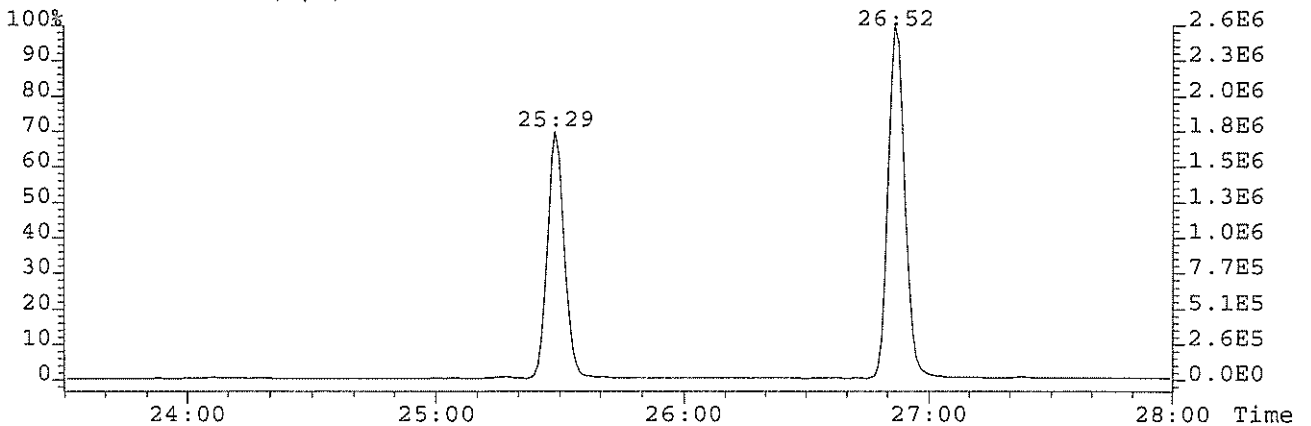
355.8546 S:14 SMO(1,3)



365.8978 S:14 SMO(1,3)



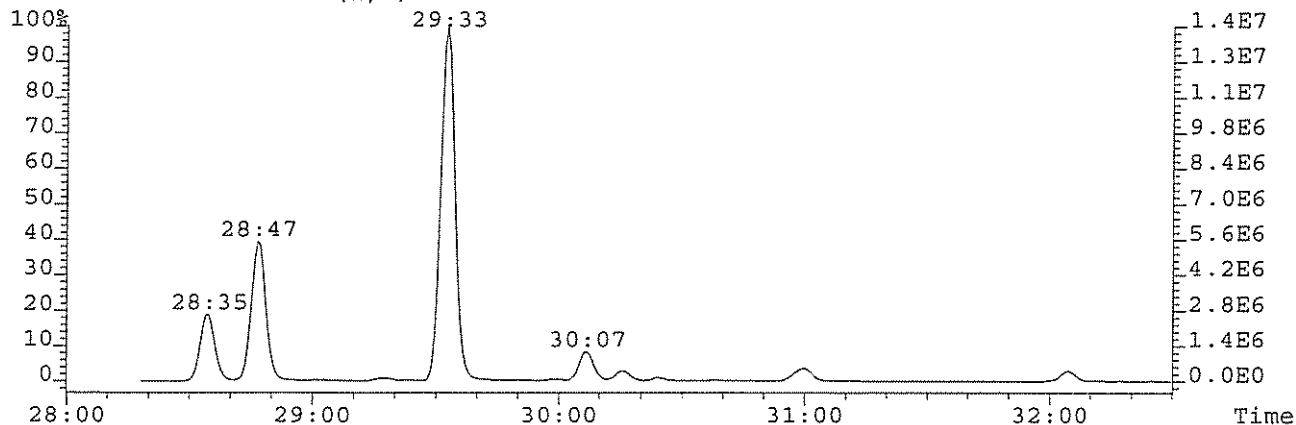
367.8949 S:14 SMO(1,3)



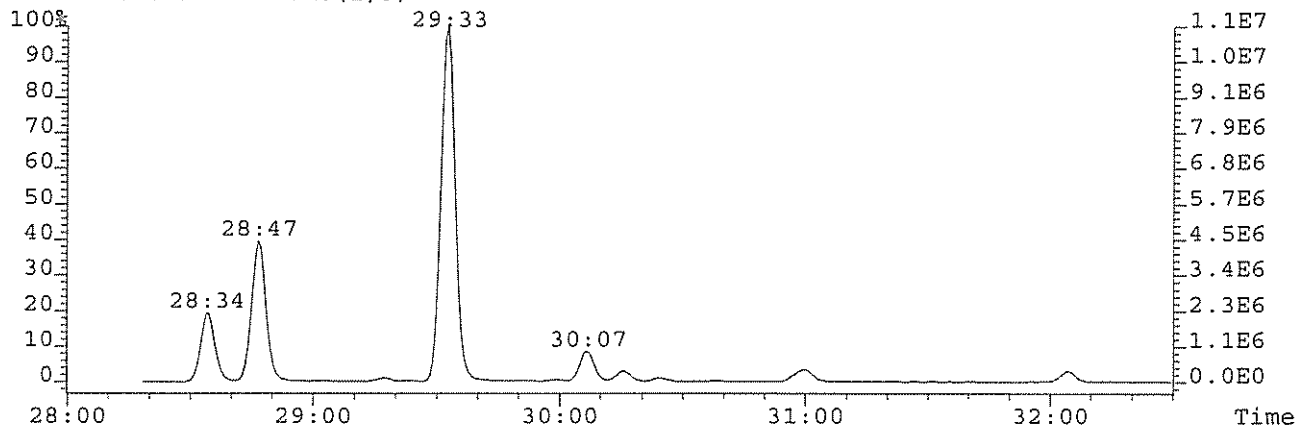
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130712-2 #1-1117 Acq:13-JUL-2013 02:53:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:BPX-DXN(4-6DXN) Text:XE13 0957 Exp:BPX04

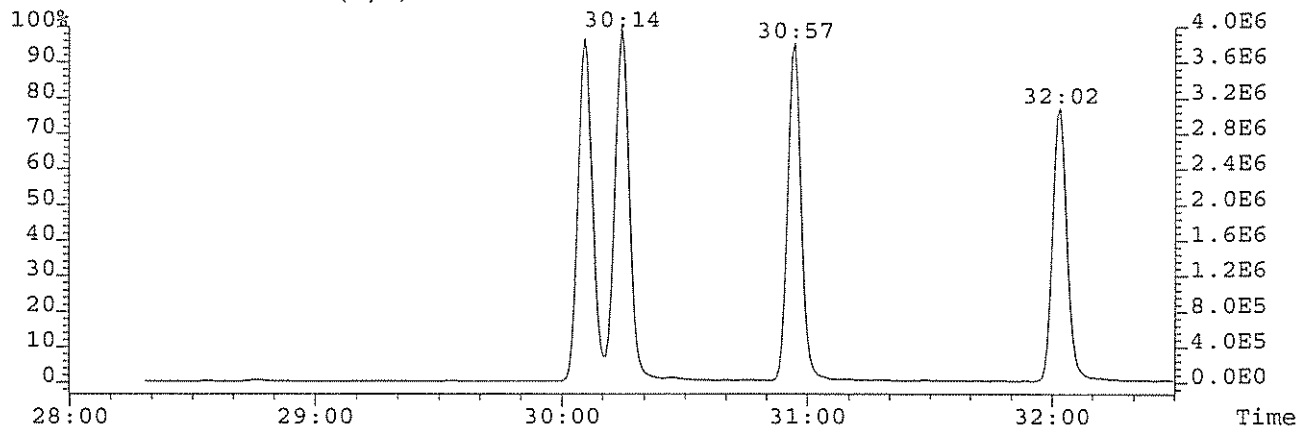
373.8207 S:14 F:2 SMO(1,3)



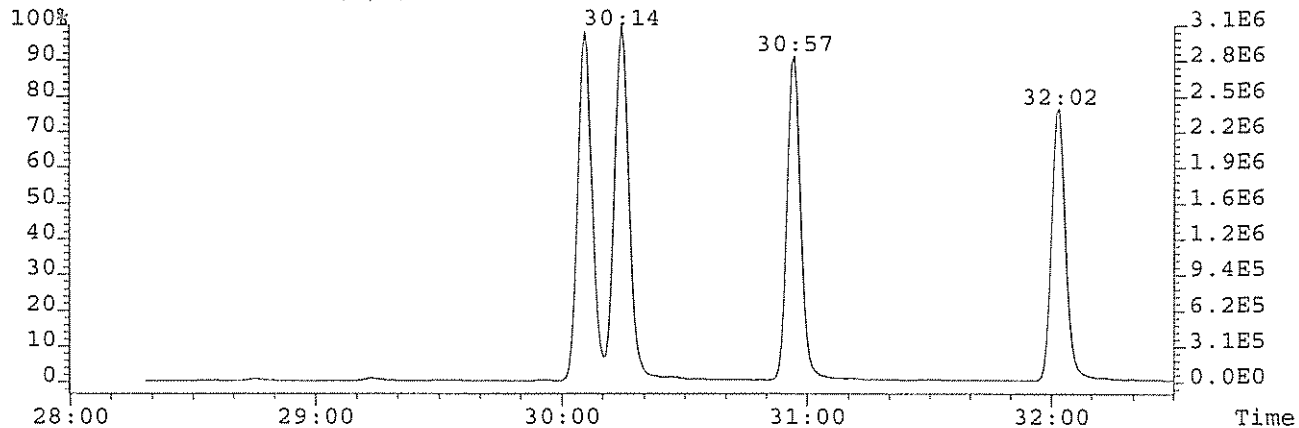
375.8178 S:14 F:2 SMO(1,3)



385.8610 S:14 F:2 SMO(1,3)



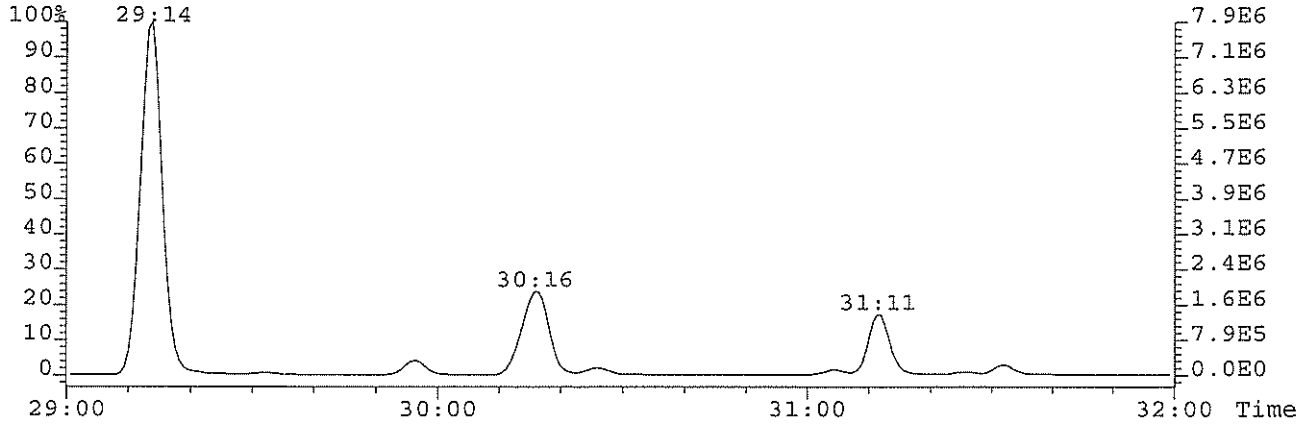
387.8580 S:14 F:2 SMO(1,3)



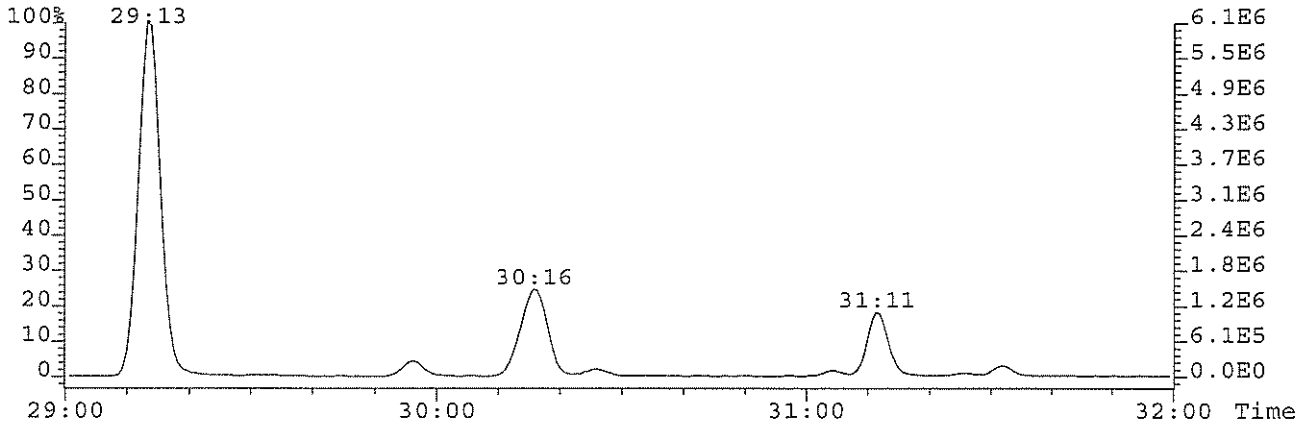
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1117 Acq:13-JUL-2013 02:53:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:BPX-DXN(4-6DXN) Text:XE13 0957 Exp:BPX04

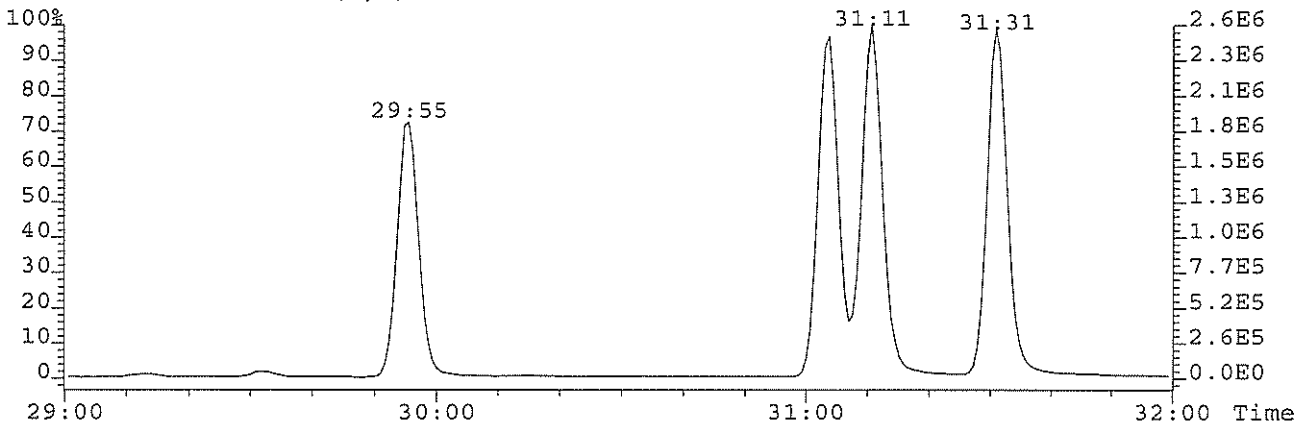
389.8156 S:14 F:2 SMO(1,3)



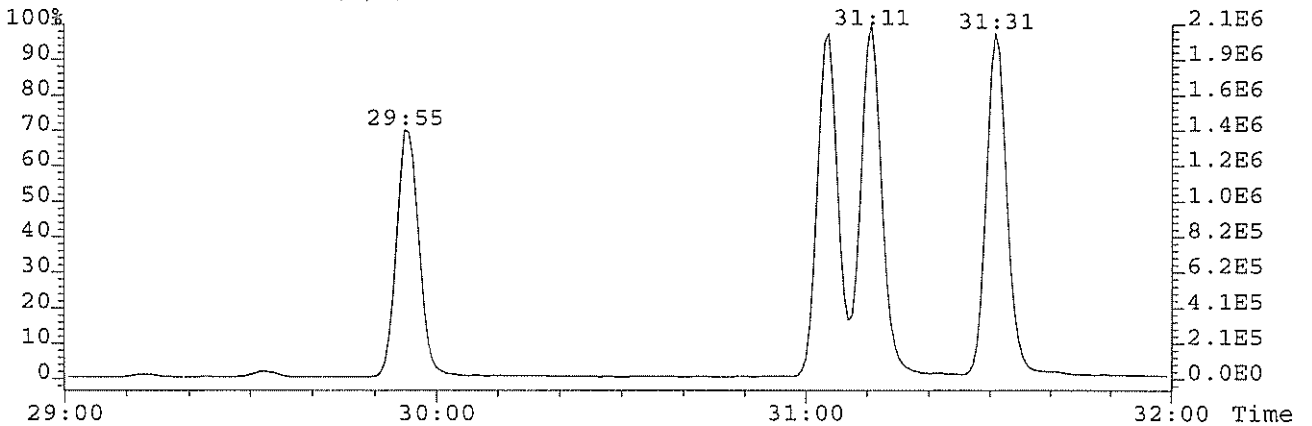
391.8127 S:14 F:2 SMO(1,3)



401.8559 S:14 F:2 SMO(1,3)



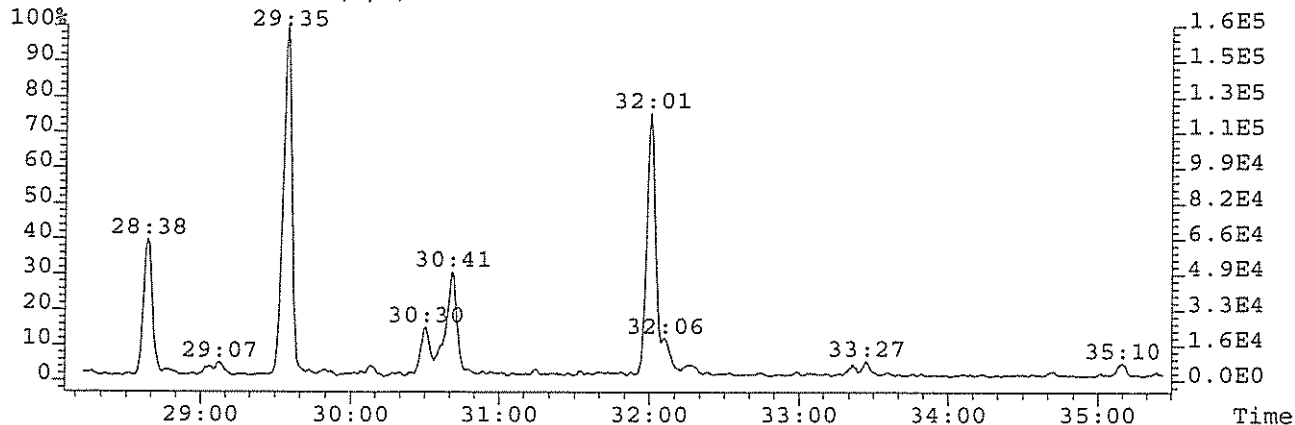
403.8530 S:14 F:2 SMO(1,3)



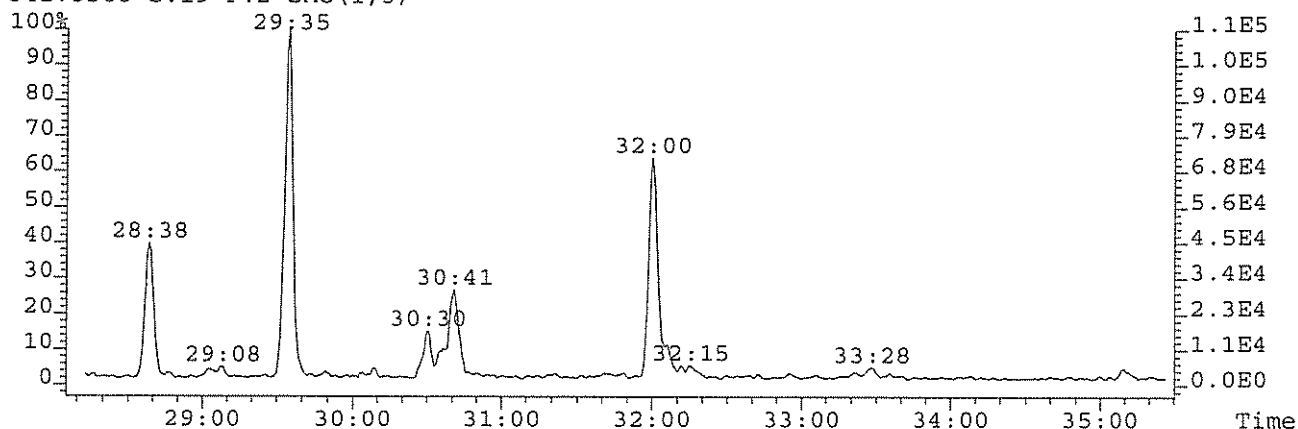
PCDDsクロマトグラム (6)  
(HxCDDs)

File:130711-2 #1-649 Acq:12-JUL-2013 09:43:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0957 3 Exp:RH-PD22

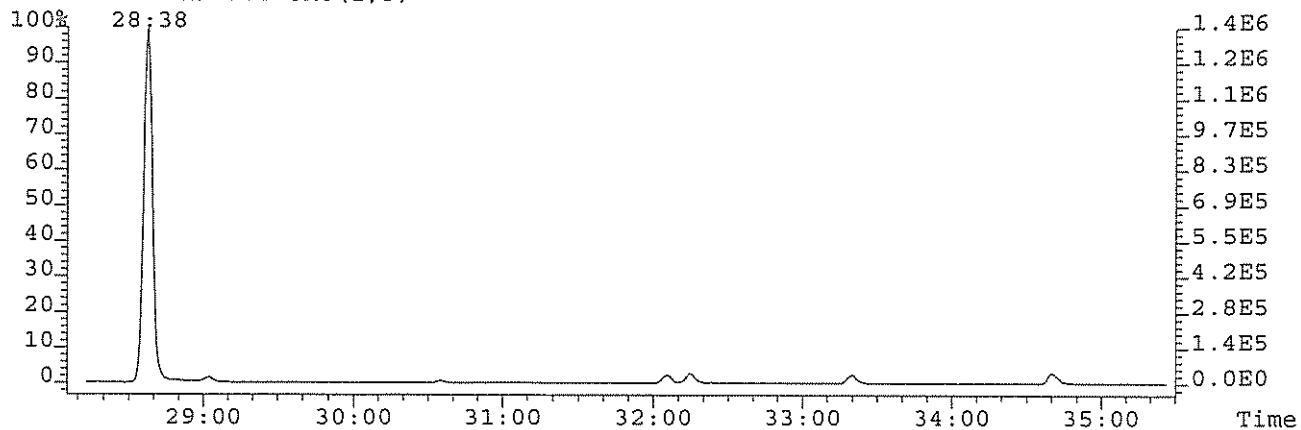
339.8597 S:19 F:2 SMO(1,3)



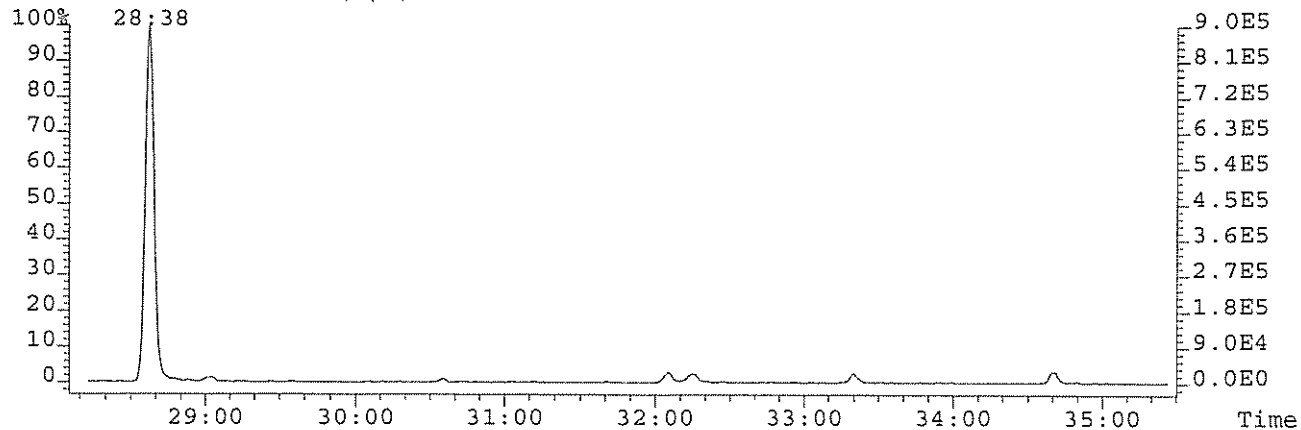
341.8568 S:19 F:2 SMO(1,3)



351.9000 S:19 F:2 SMO(1,3)



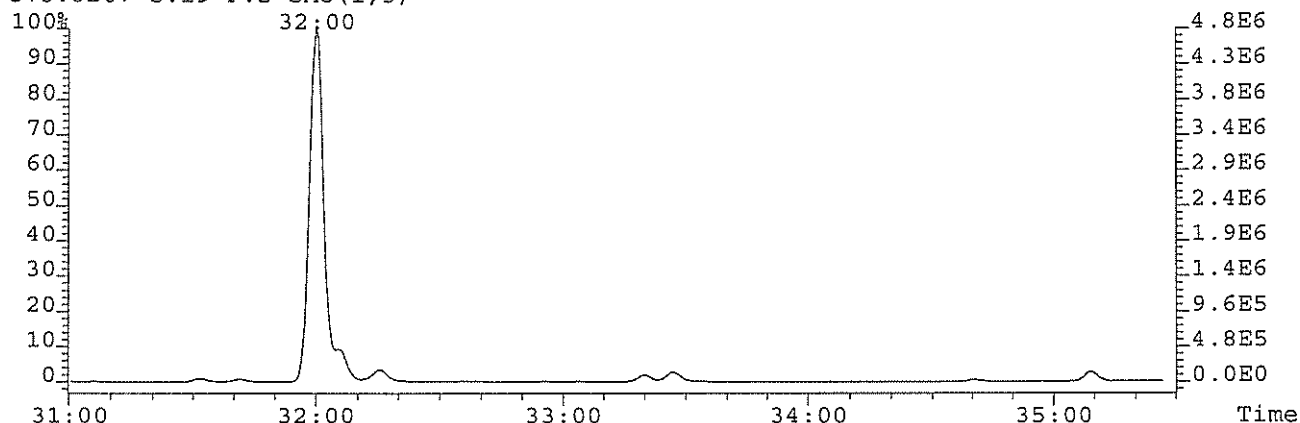
353.8970 S:19 F:2 SMO(1,3)



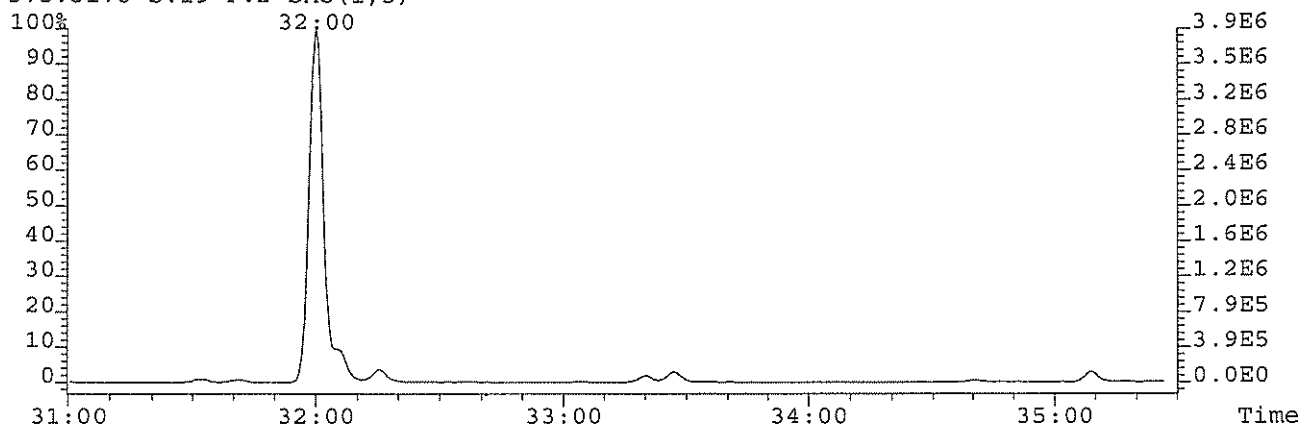
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130711-2 #1-649 Acq:12-JUL-2013 09:43:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0957 3 Exp:RH-PD22

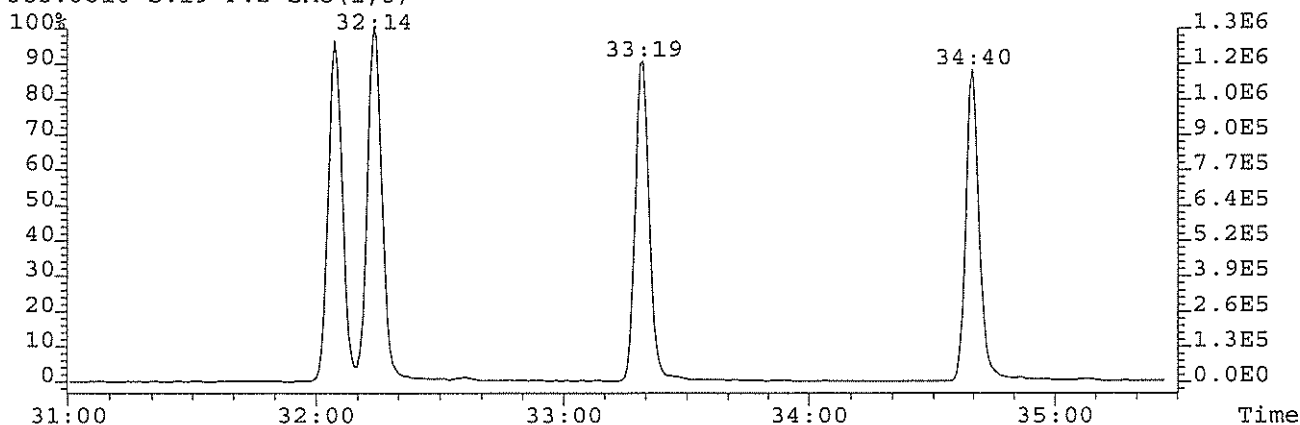
373.8207 S:19 F:2 SMO(1,3)



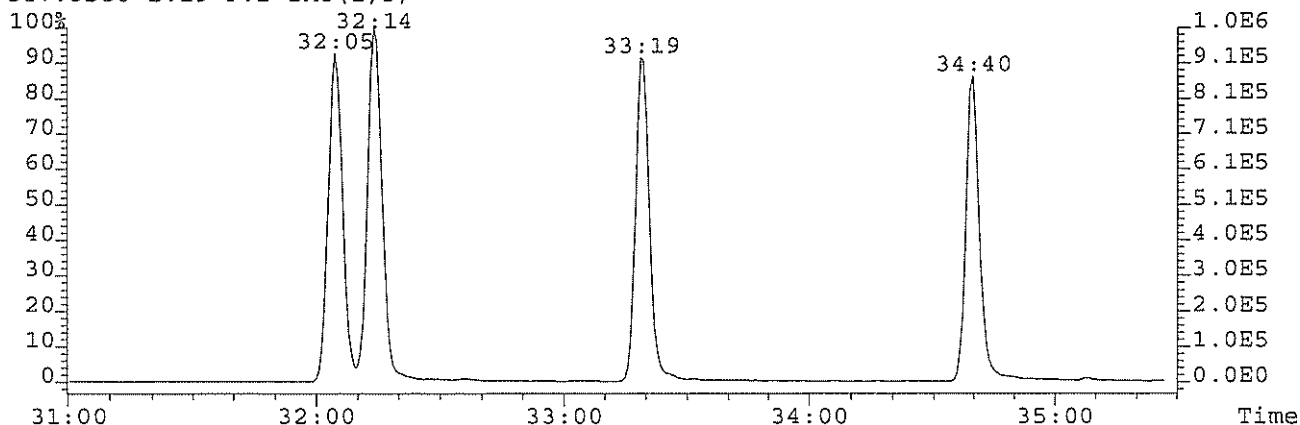
375.8178 S:19 F:2 SMO(1,3)



385.8610 S:19 F:2 SMO(1,3)

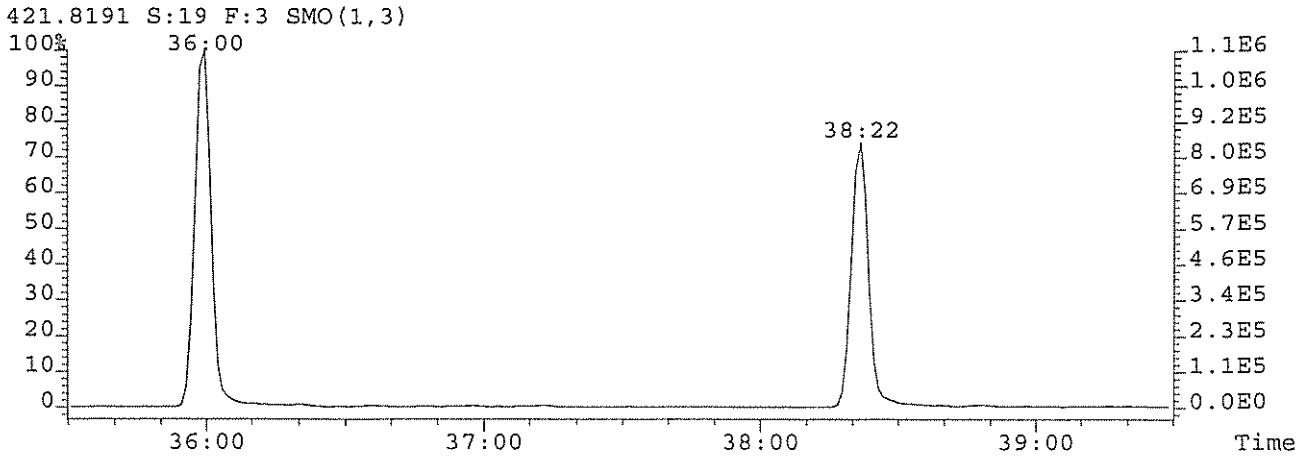
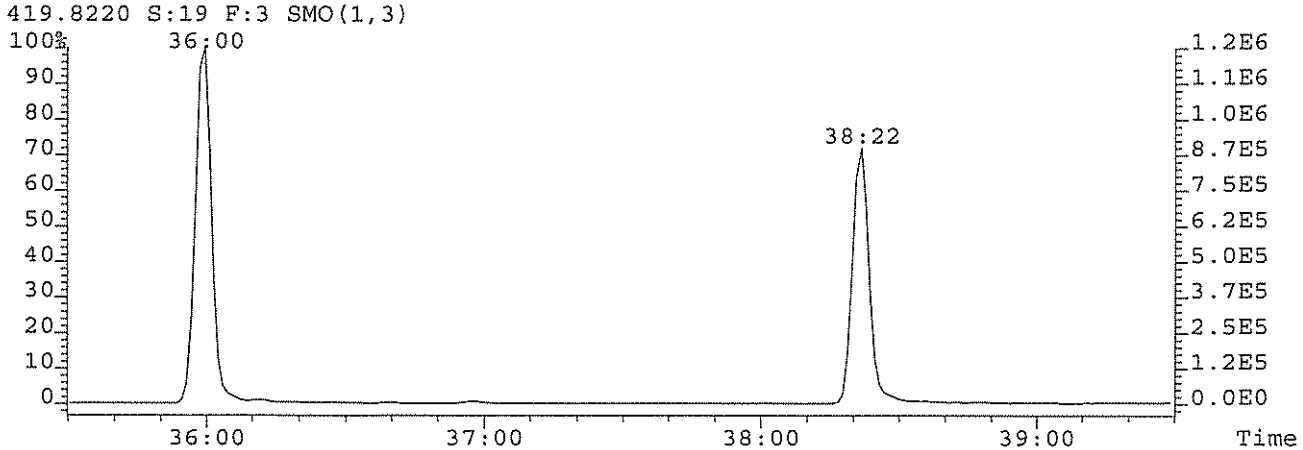
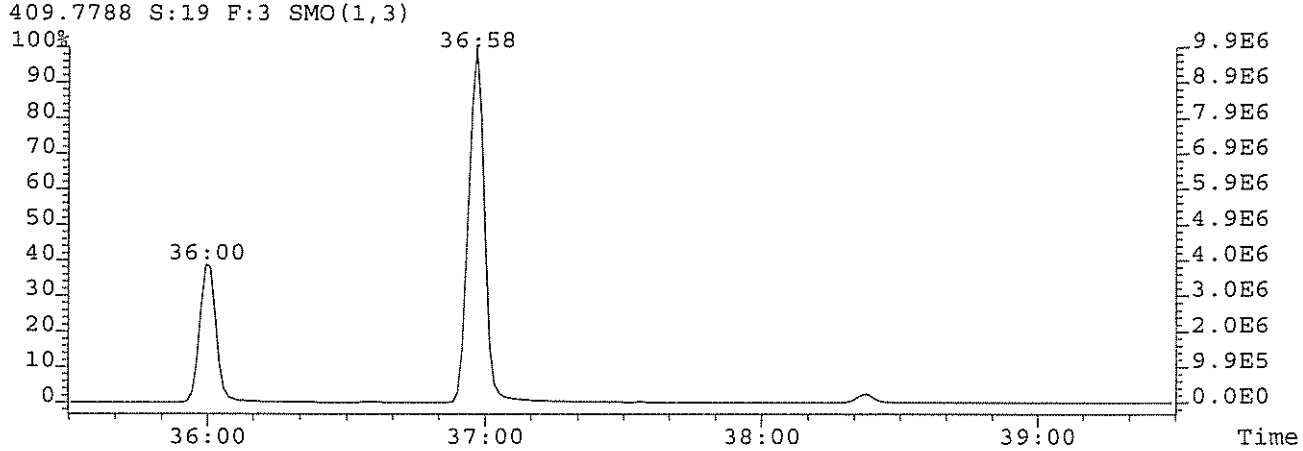
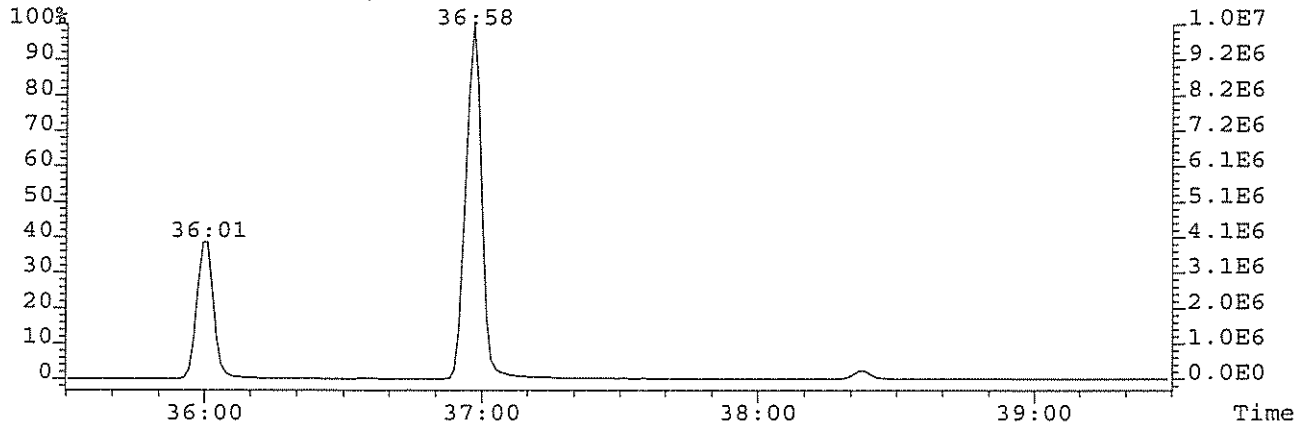


387.8580 S:19 F:2 SMO(1,3)



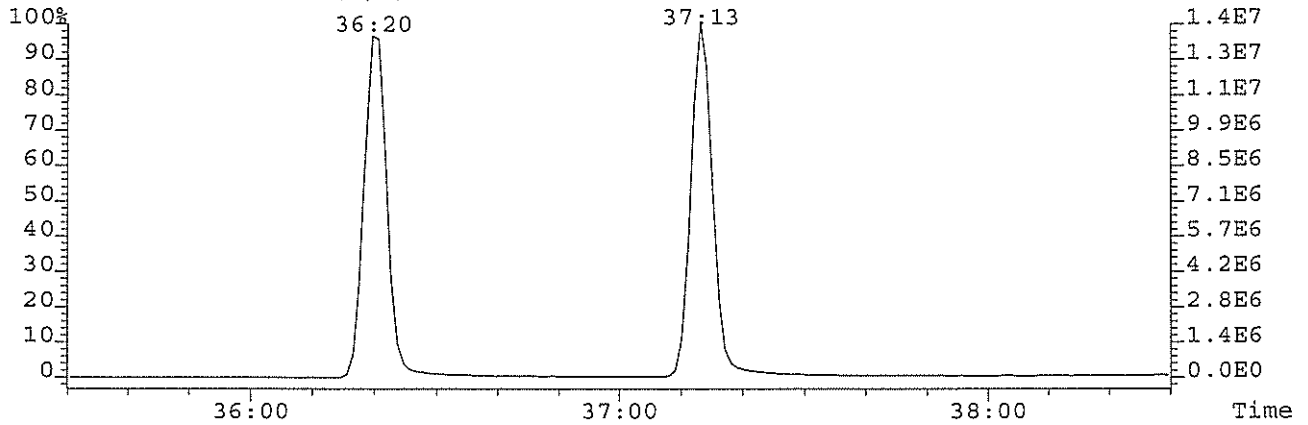
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130711-2 #1-561 Acq:12-JUL-2013 09:43:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0957 3 Exp:RH-PD22  
407.7818 S:19 F:3 SMO(1,3)

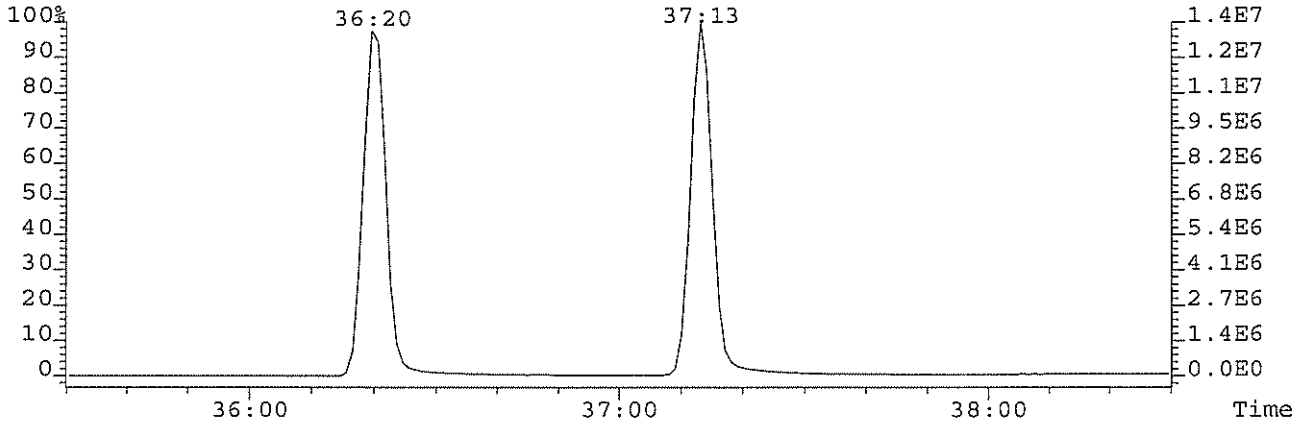


PCDFsクロマトグラム (9)  
(HpCDFs)

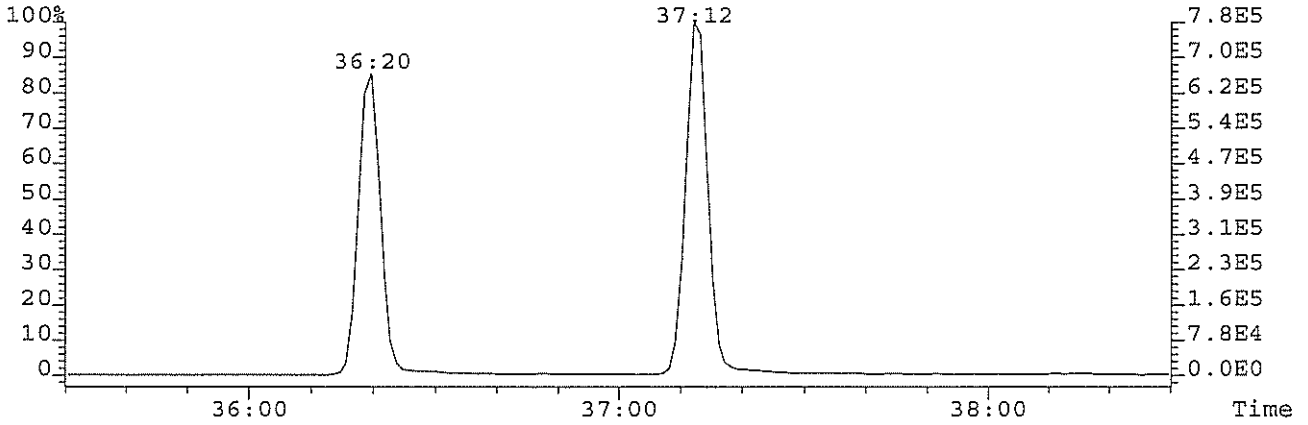
File:130711-2 #1-561 Acq:12-JUL-2013 09:43:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0957 3 Exp:RH-PD22  
423.7767 S:19 F:3 SMO(1,3)



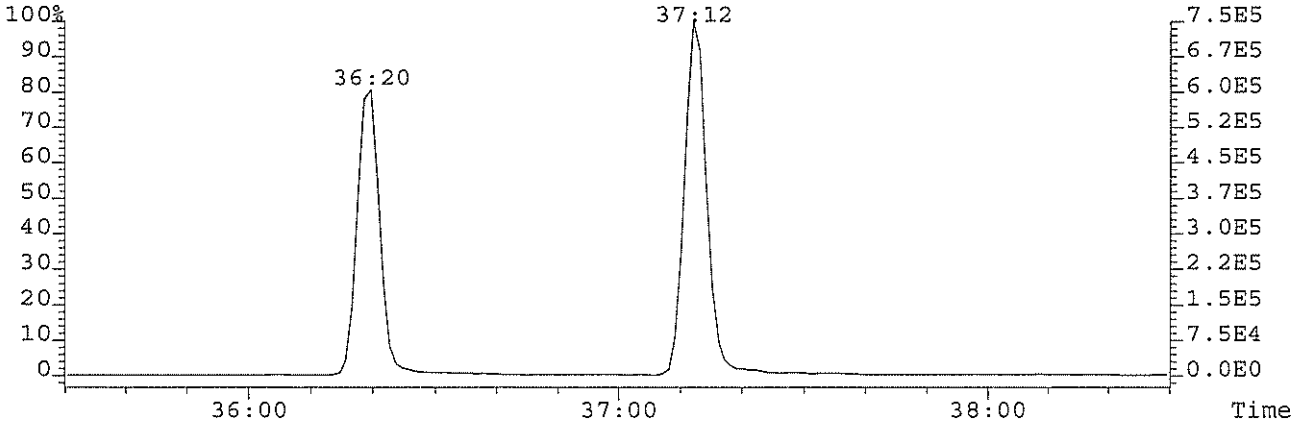
425.7737 S:19 F:3 SMO(1,3)



435.8169 S:19 F:3 SMO(1,3)



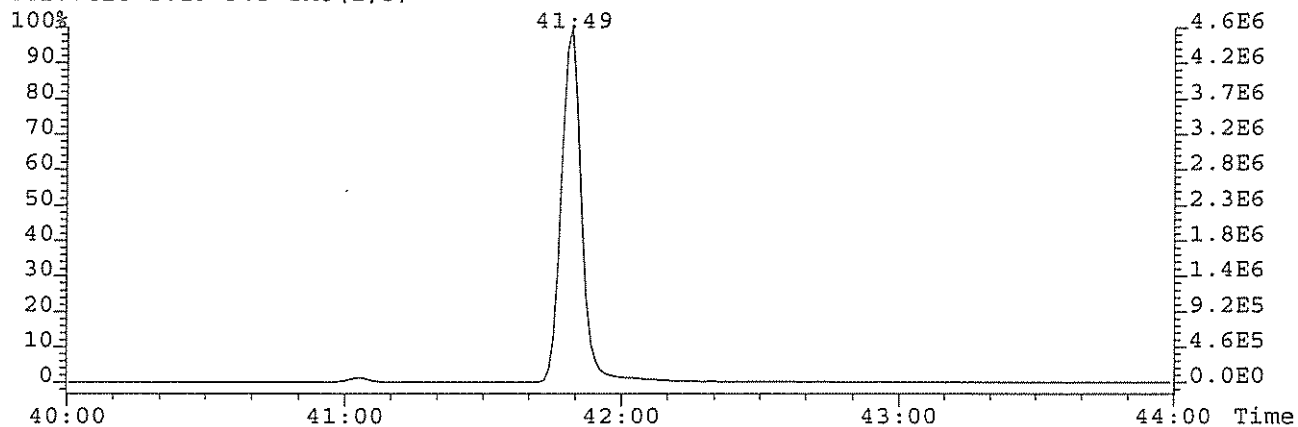
437.8140 S:19 F:3 SMO(1,3)



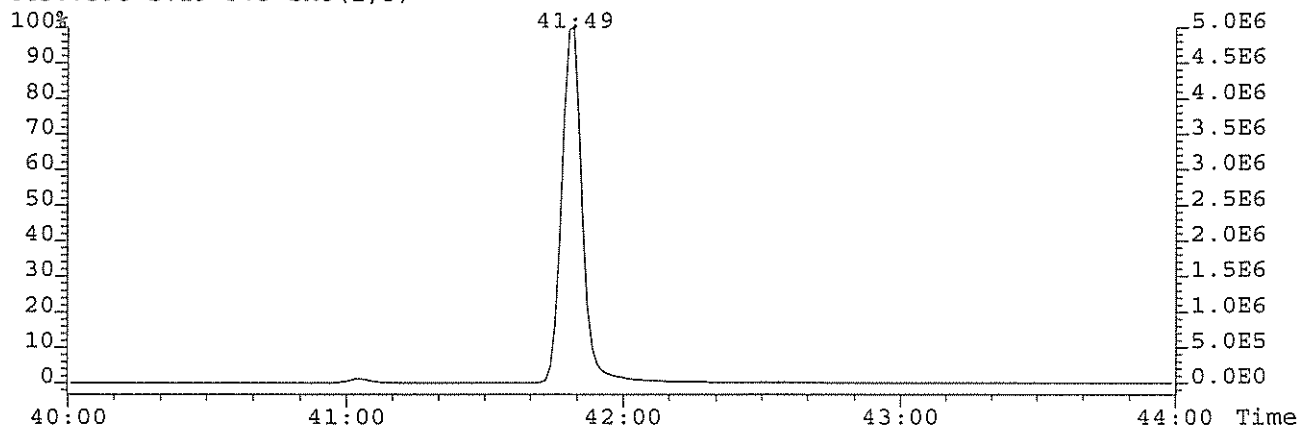
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130711-2 #1-561 Acq:12-JUL-2013 09:43:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0957 3 Exp:RH-PD22

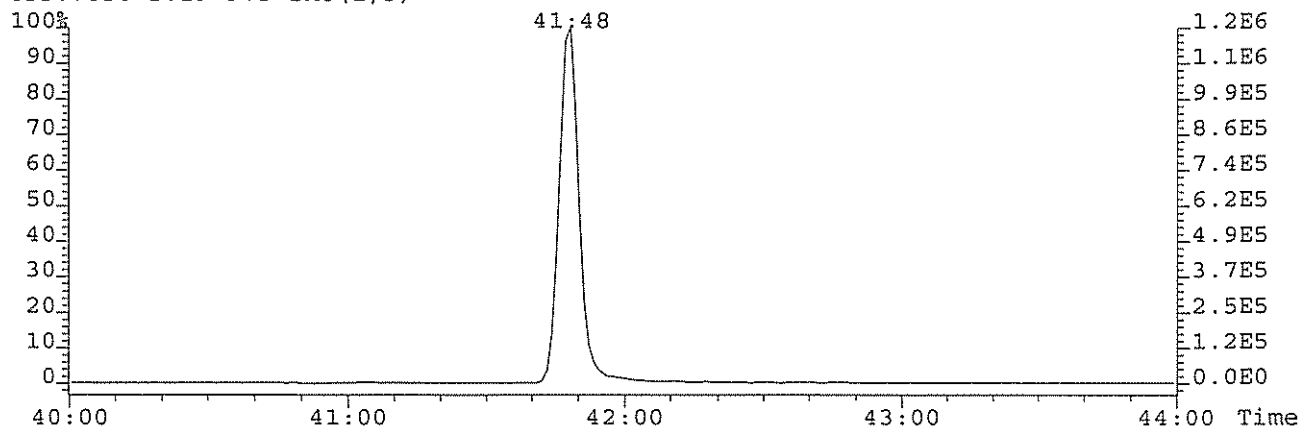
441.7428 S:19 F:3 SMO(1,3)



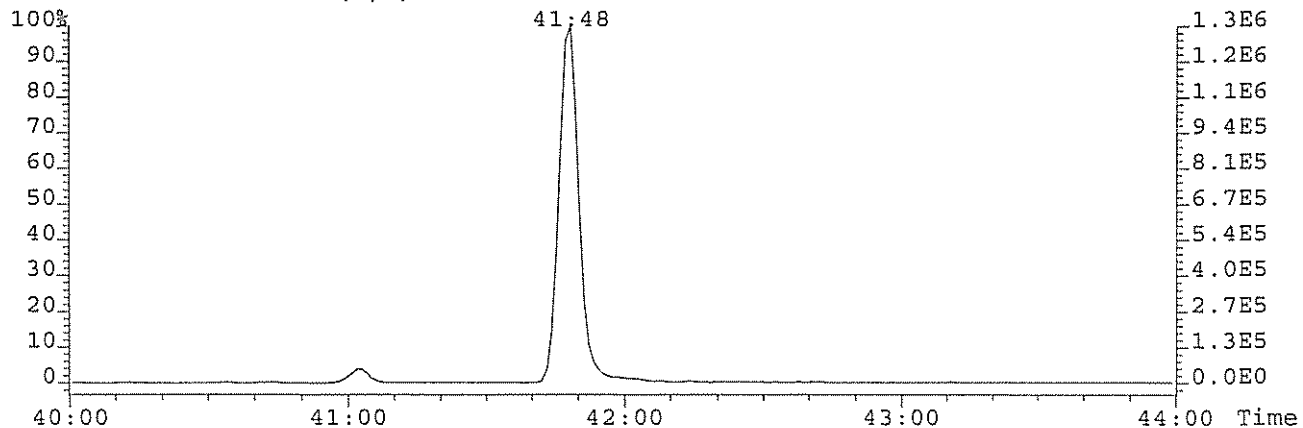
443.7398 S:19 F:3 SMO(1,3)



453.7830 S:19 F:3 SMO(1,3)



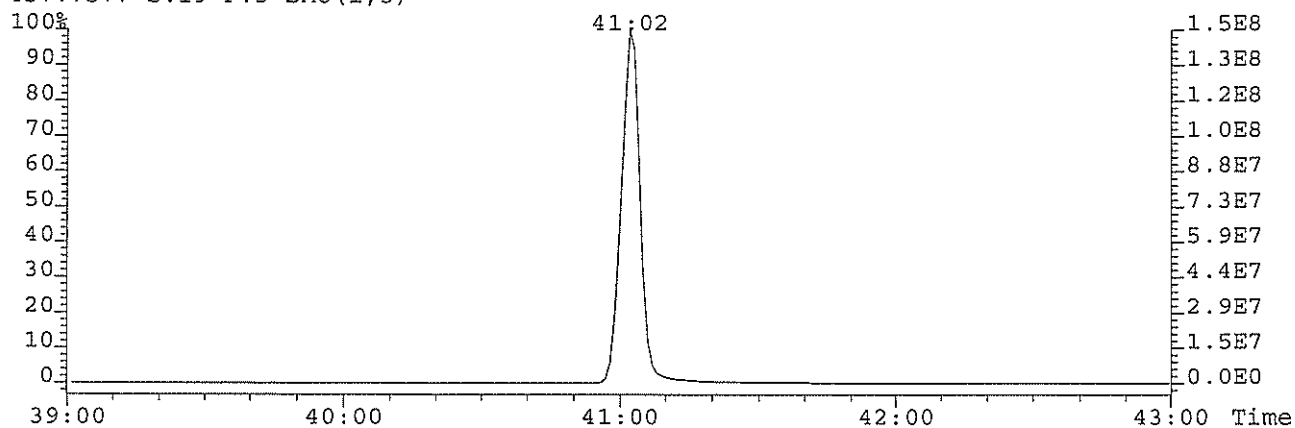
455.7801 S:19 F:3 SMO(1,3)



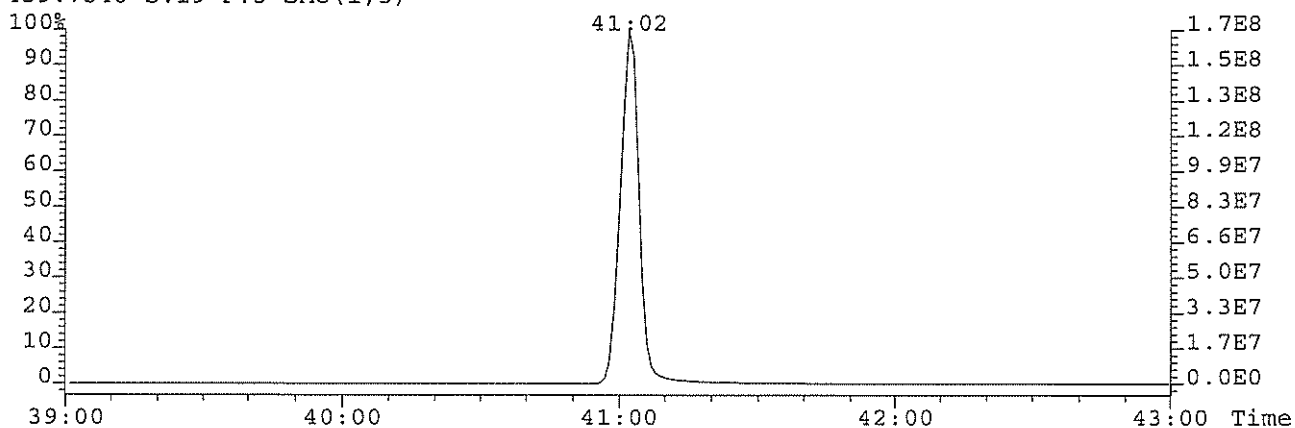


File:130711-2 #1-561 Acq:12-JUL-2013 09:43:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0957 3 Exp:RH-PD22

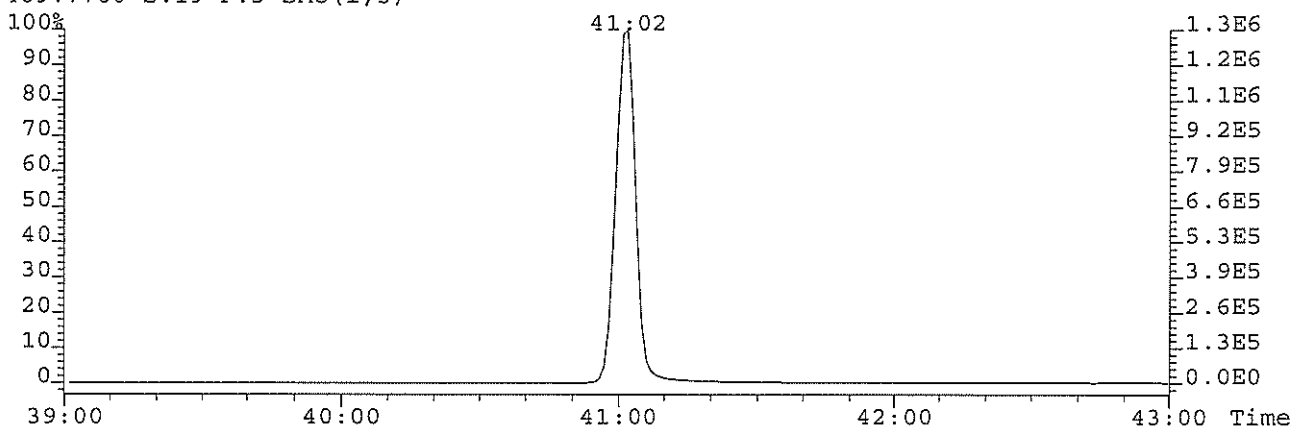
457.7377 S:19 F:3 SMO(1,3)



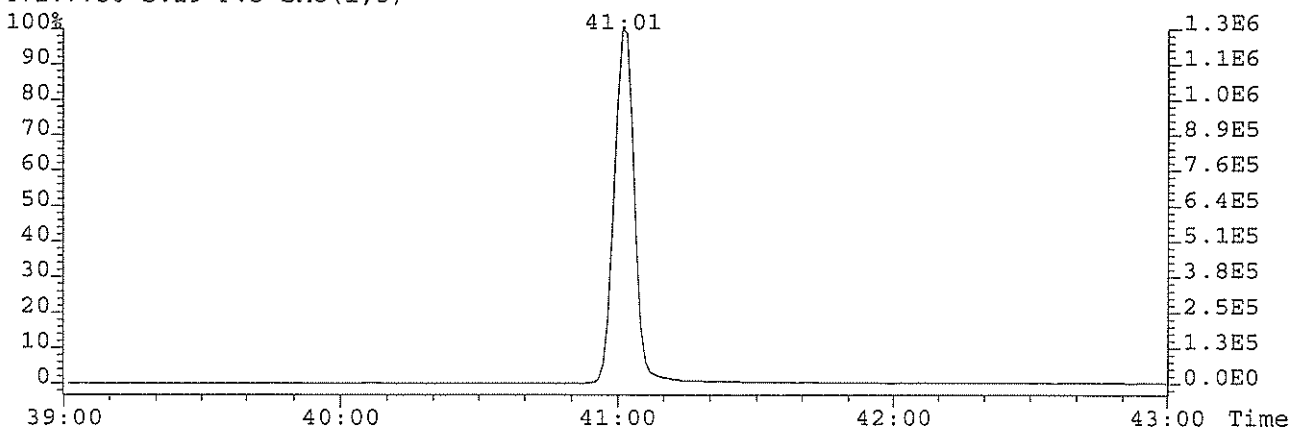
459.7348 S:19 F:3 SMO(1,3)



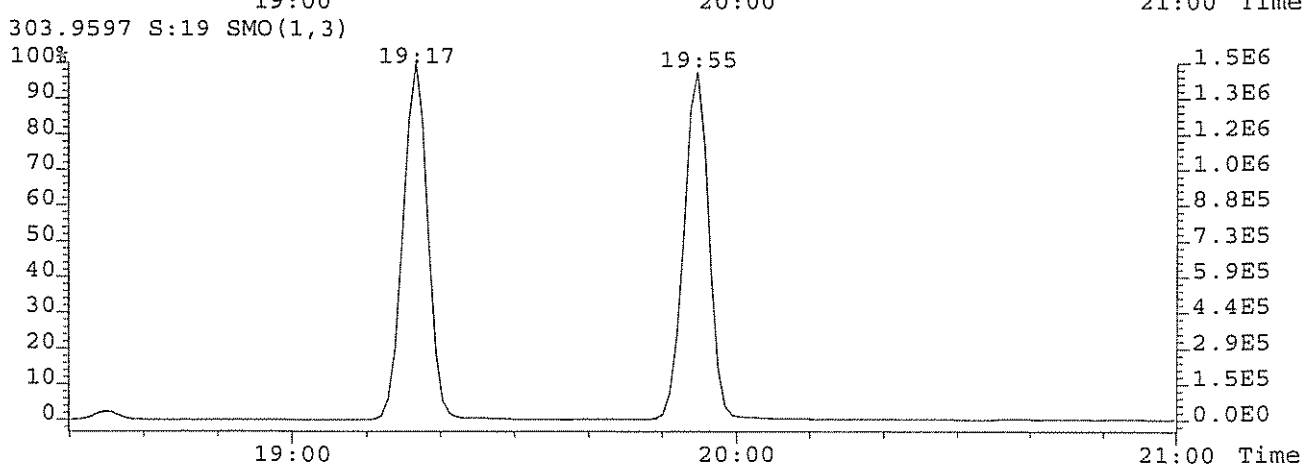
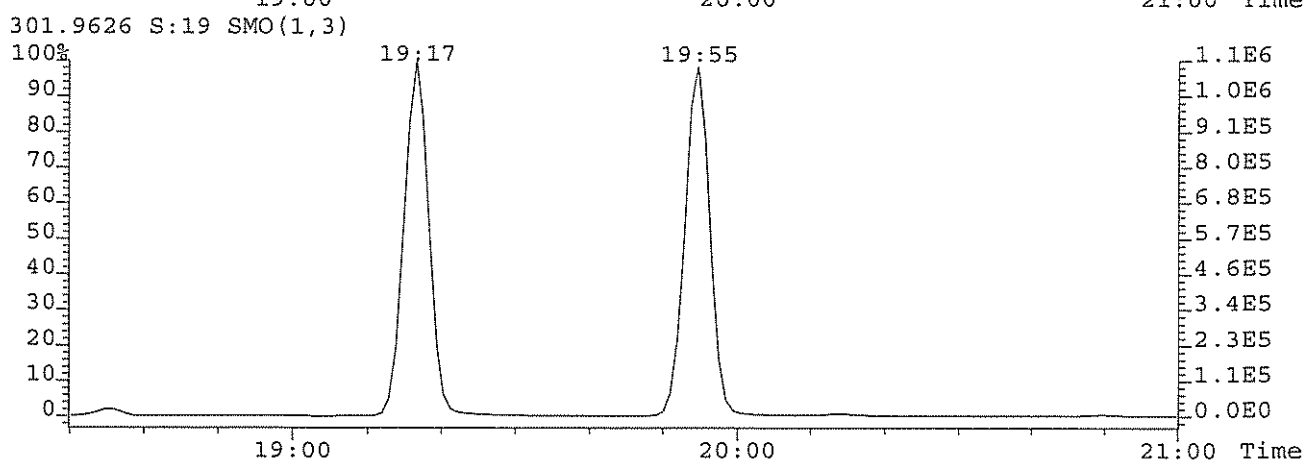
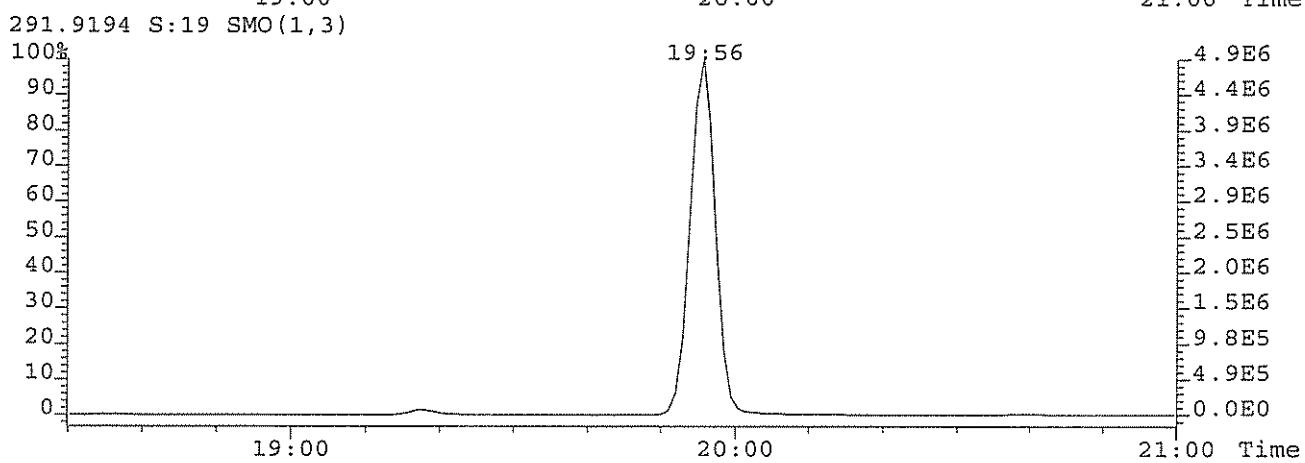
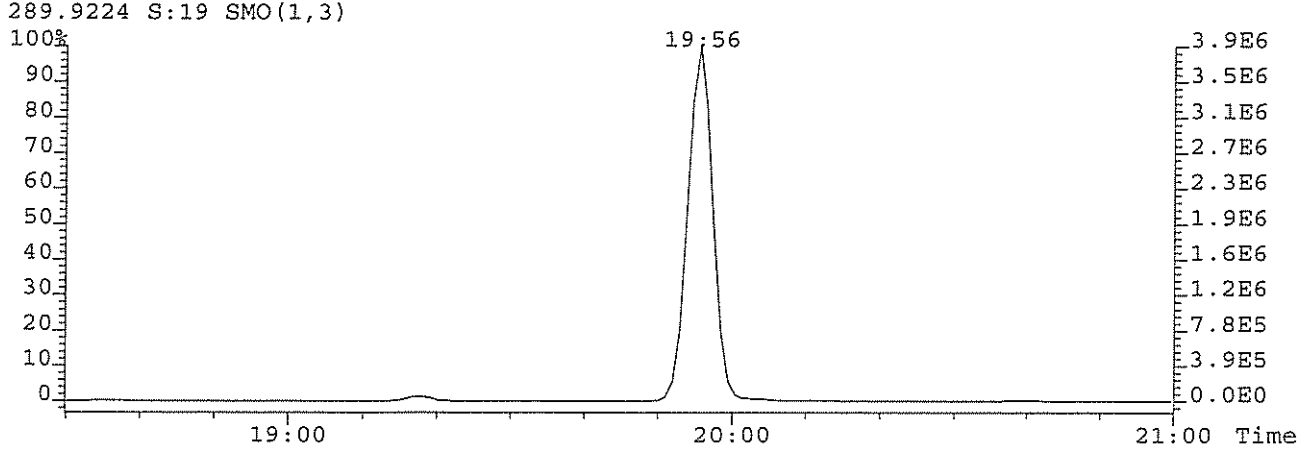
469.7780 S:19 F:3 SMO(1,3)



471.7750 S:19 F:3 SMO(1,3)



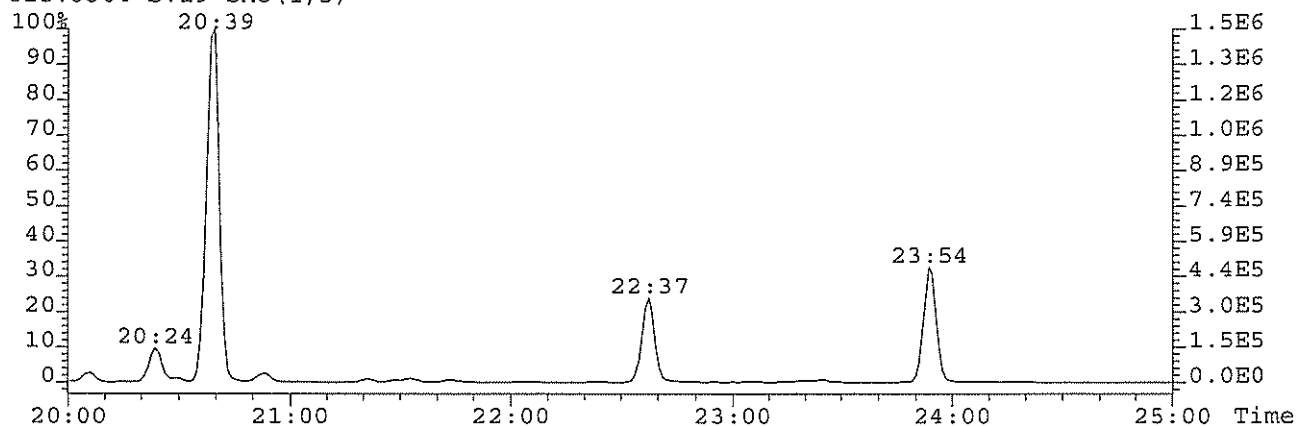
File:130711-2 #1-1430 Acq:12-JUL-2013 09:43:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0957 3 Exp:RH-PD22



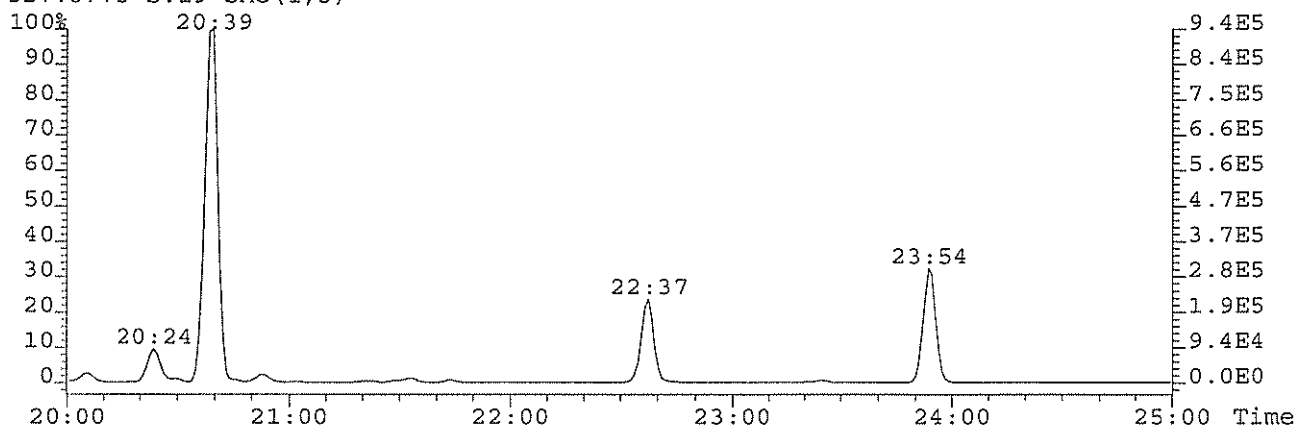
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 09:43:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0957 3 Exp:RH-PD22

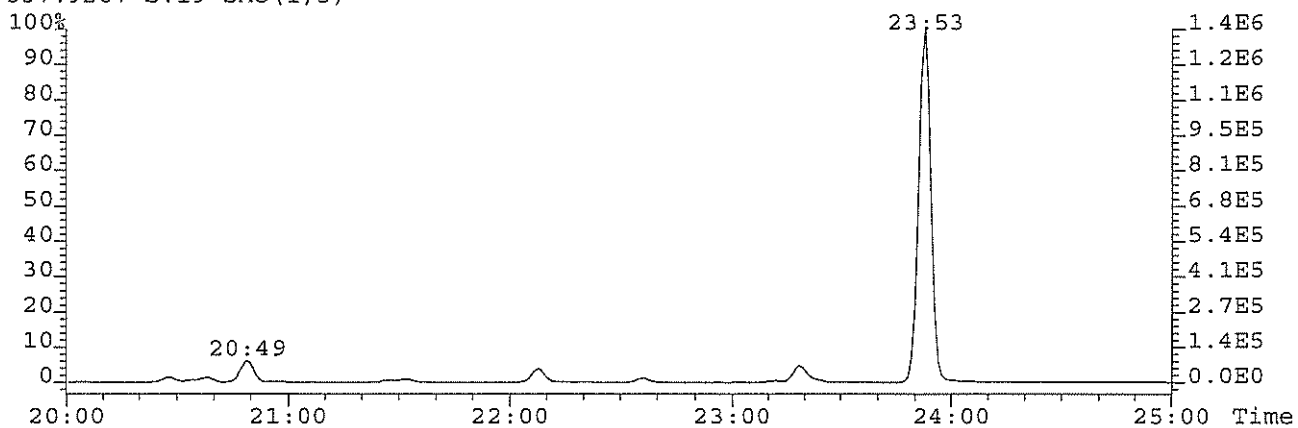
325.8804 S:19 SMO(1,3)



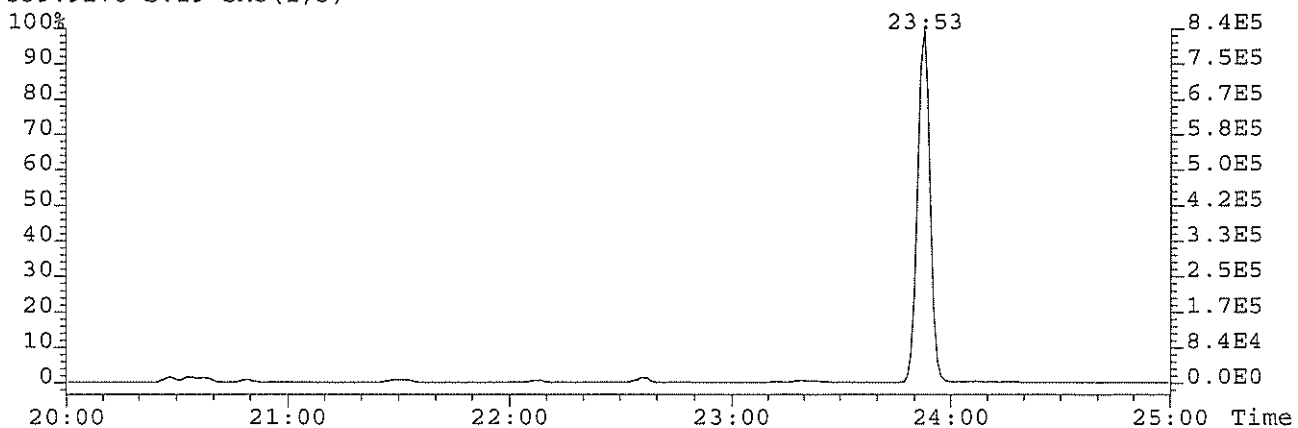
327.8775 S:19 SMO(1,3)



337.9207 S:19 SMO(1,3)

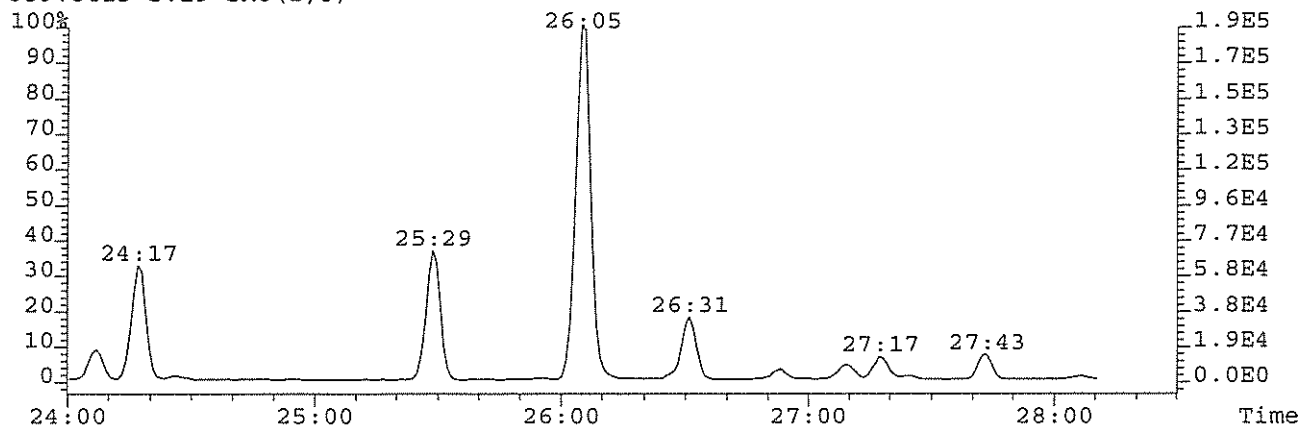


339.9178 S:19 SMO(1,3)

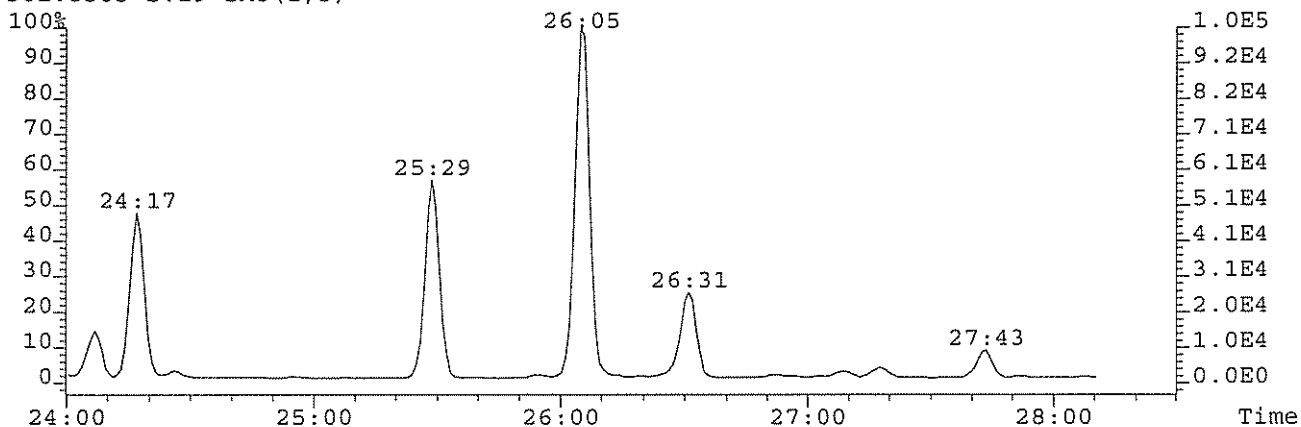


DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

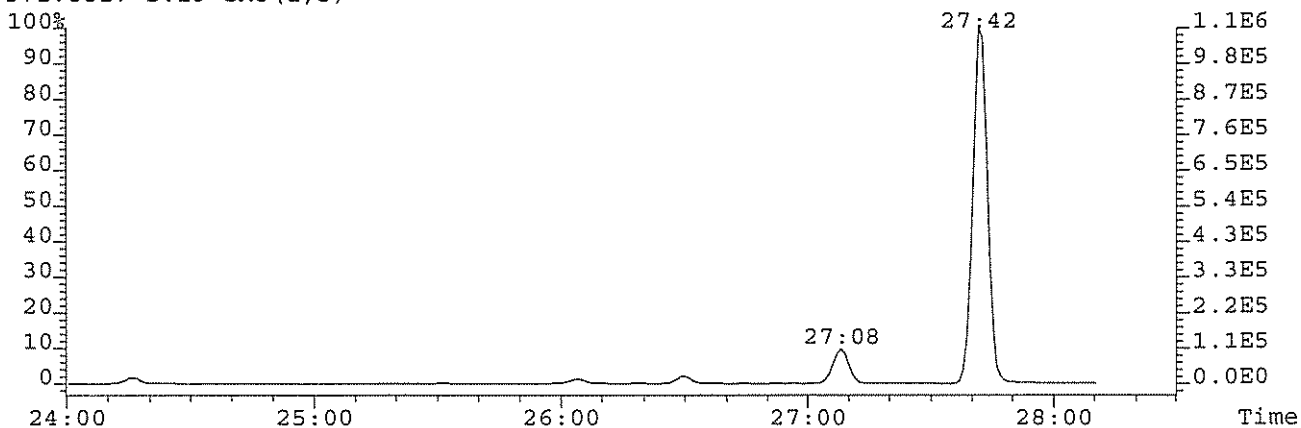
File:130711-2 #1-1430 Acq:12-JUL-2013 09:43:19 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0957 3 Exp:RH-PD22  
359.8415 S:19 SMO(1,3)



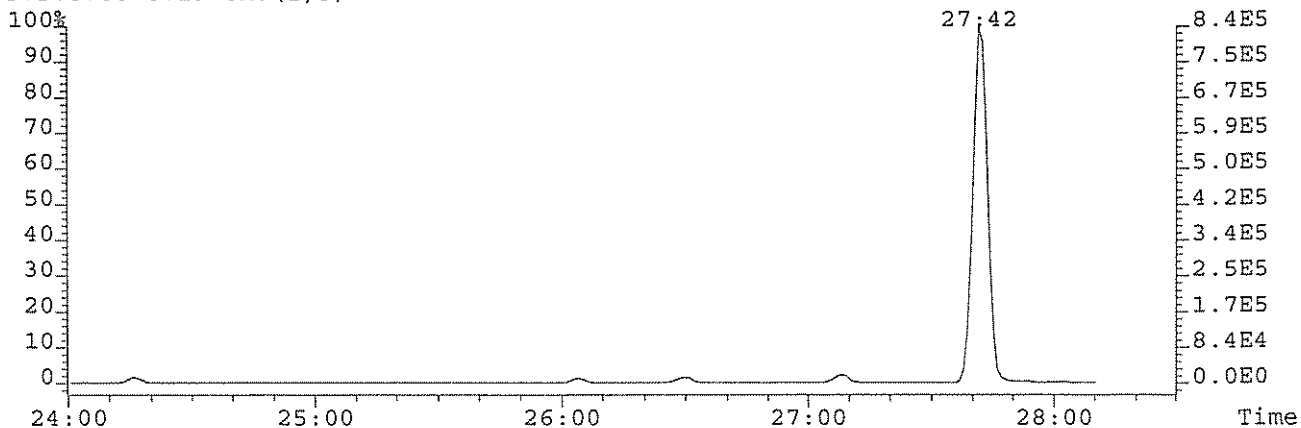
361.8385 S:19 SMO(1,3)



371.8817 S:19 SMO(1,3)



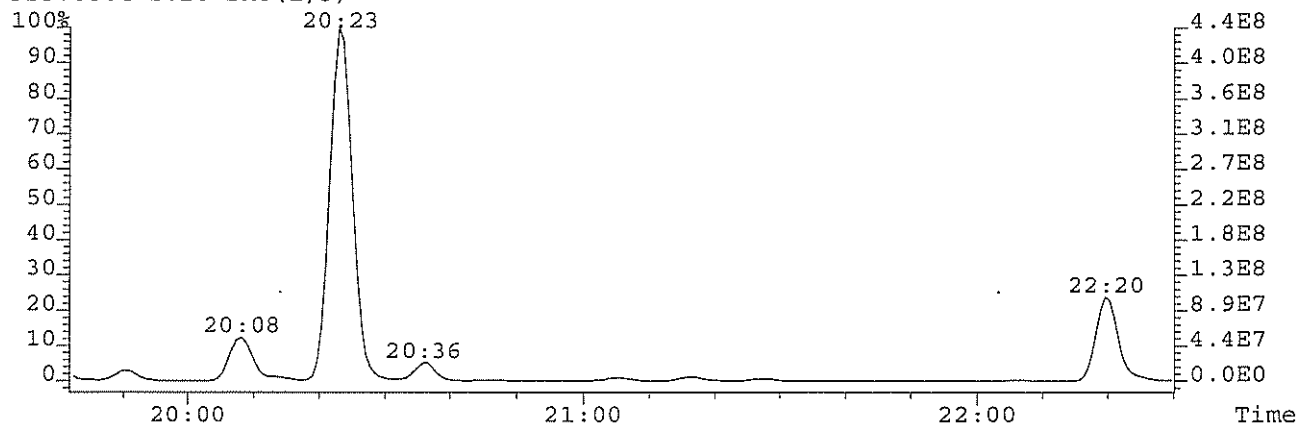
373.8788 S:19 SMO(1,3)



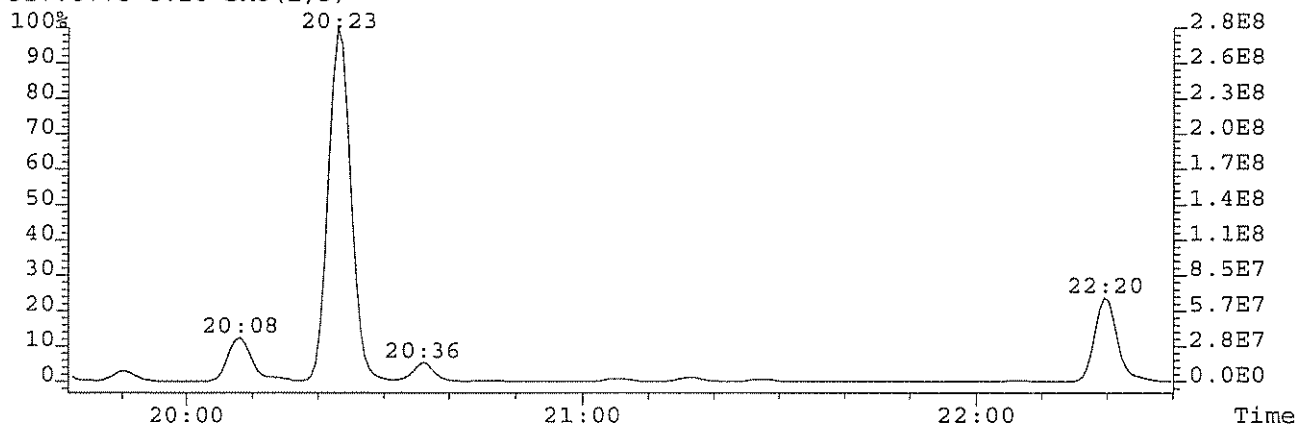
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130713 #1-2897 Acq:14-JUL-2013 05:36:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#26 File Text:RH-12ms(mP) Text:XE13 0957 2 Exp:RH-MP11

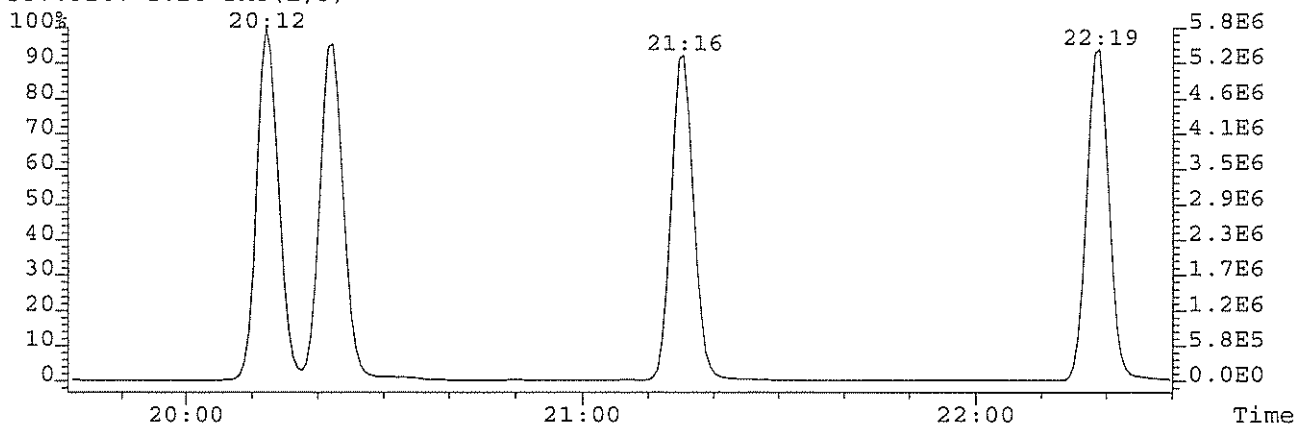
325.8804 S:26 SMO(1,3)



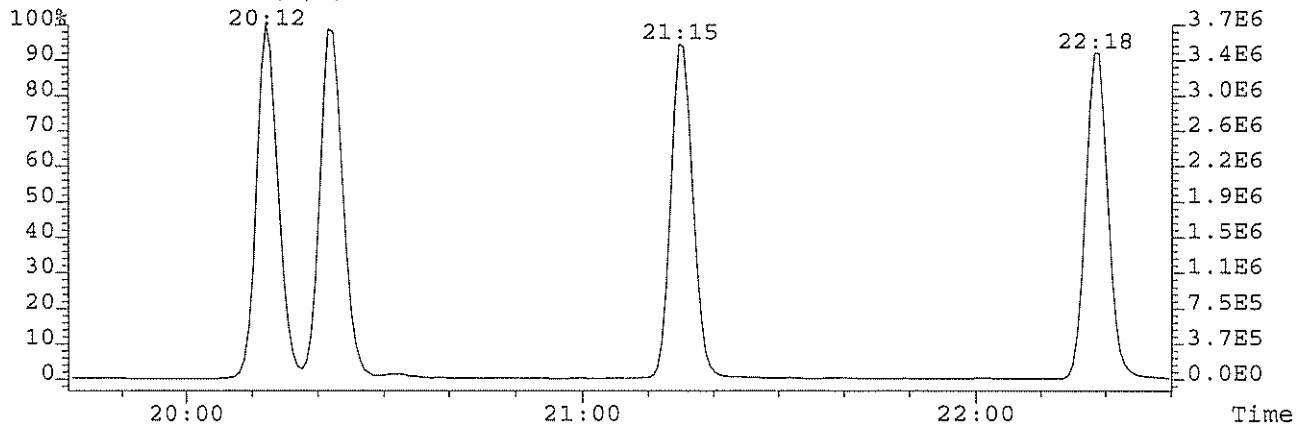
327.8775 S:26 SMO(1,3)



337.9207 S:26 SMO(1,3)



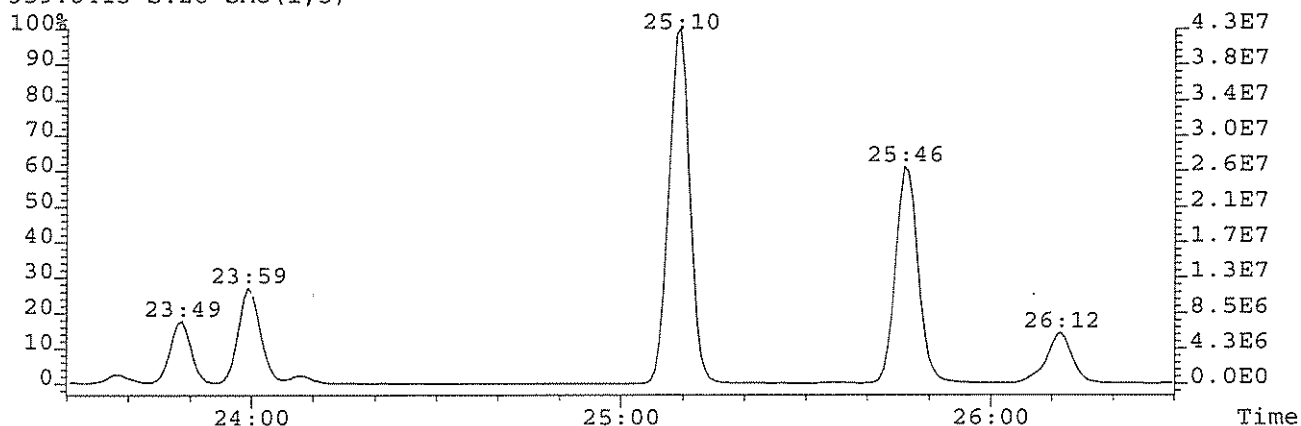
339.9178 S:26 SMO(1,3)



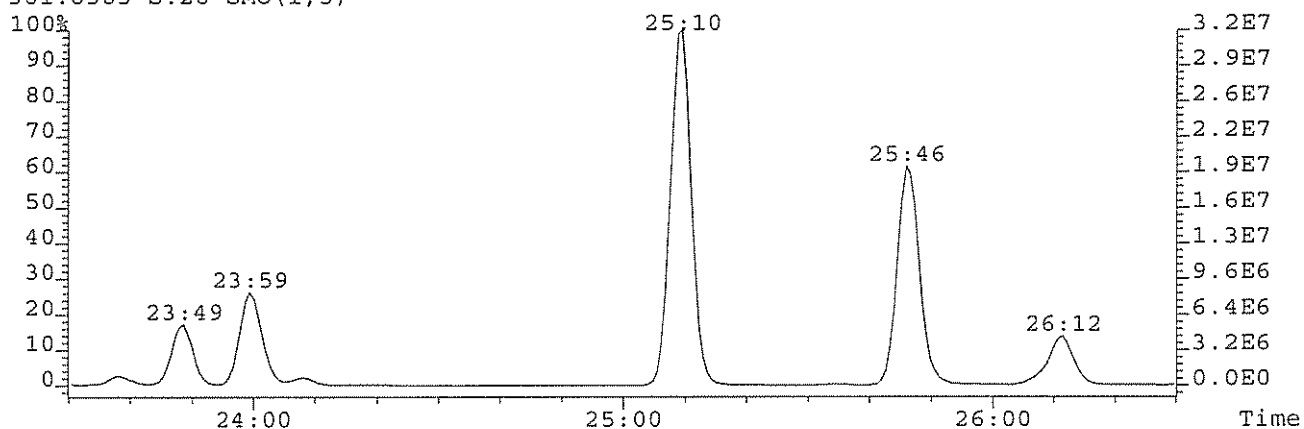
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130713 #1-2897 Acq:14-JUL-2013 05:36:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#26 File Text:RH-12ms(mP) Text:XE13 0957 2 Exp:RH-MP11

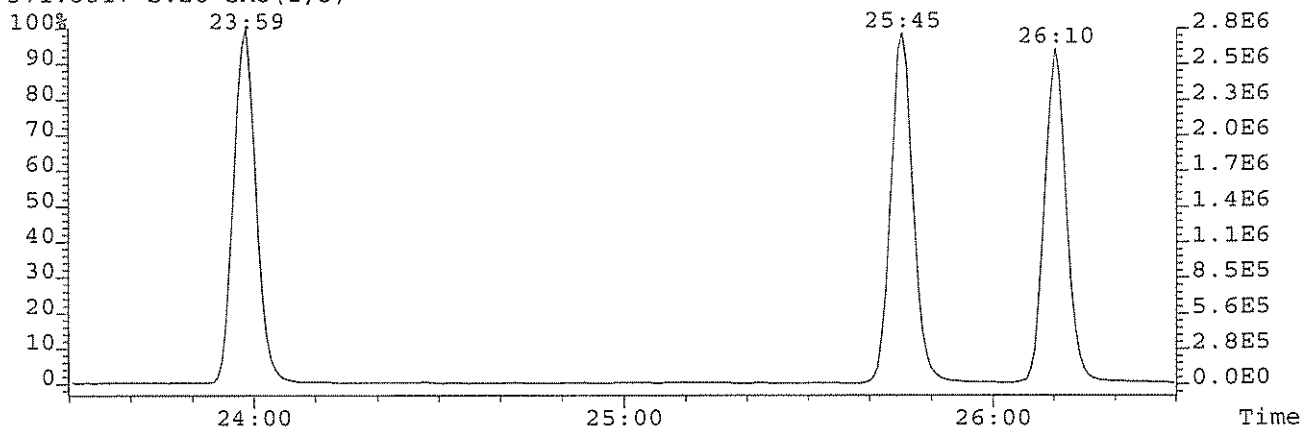
359.8415 S:26 SMO(1,3)



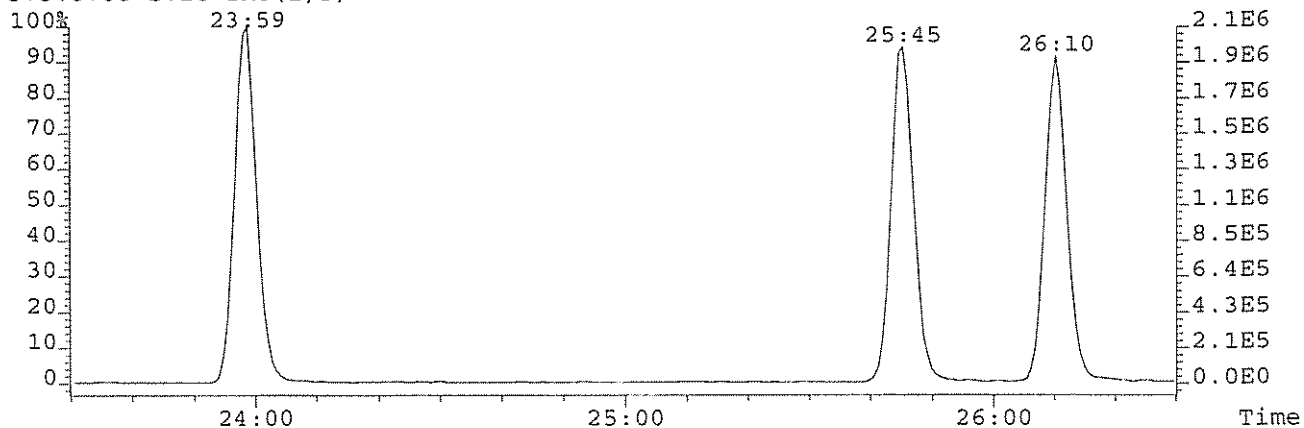
361.8385 S:26 SMO(1,3)



371.8817 S:26 SMO(1,3)

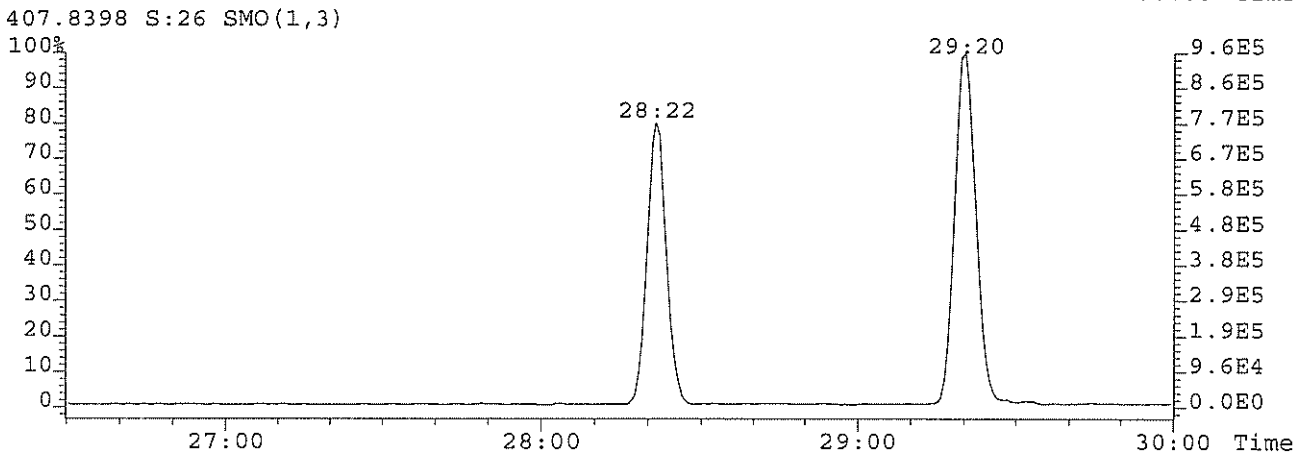
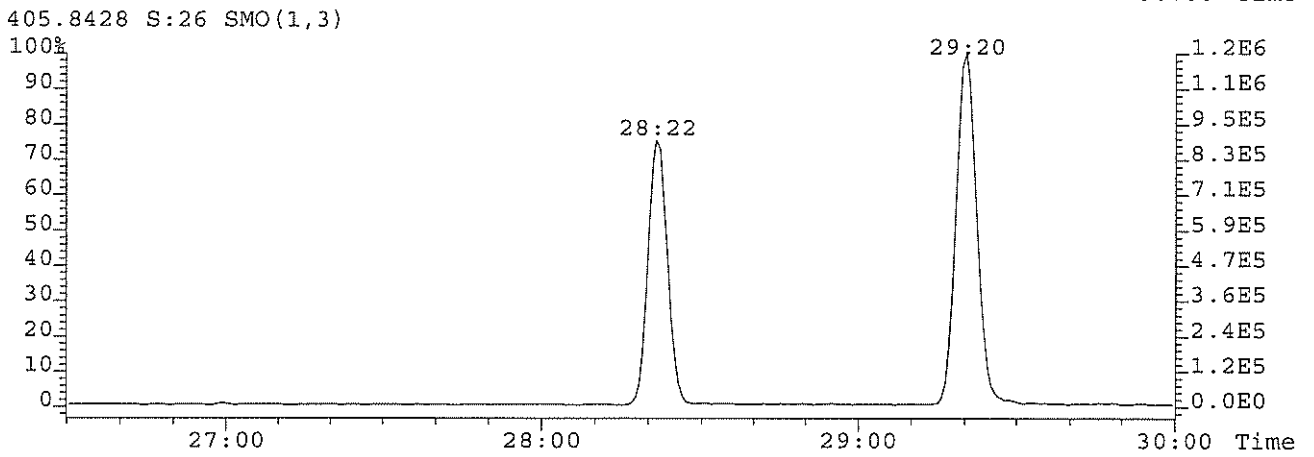
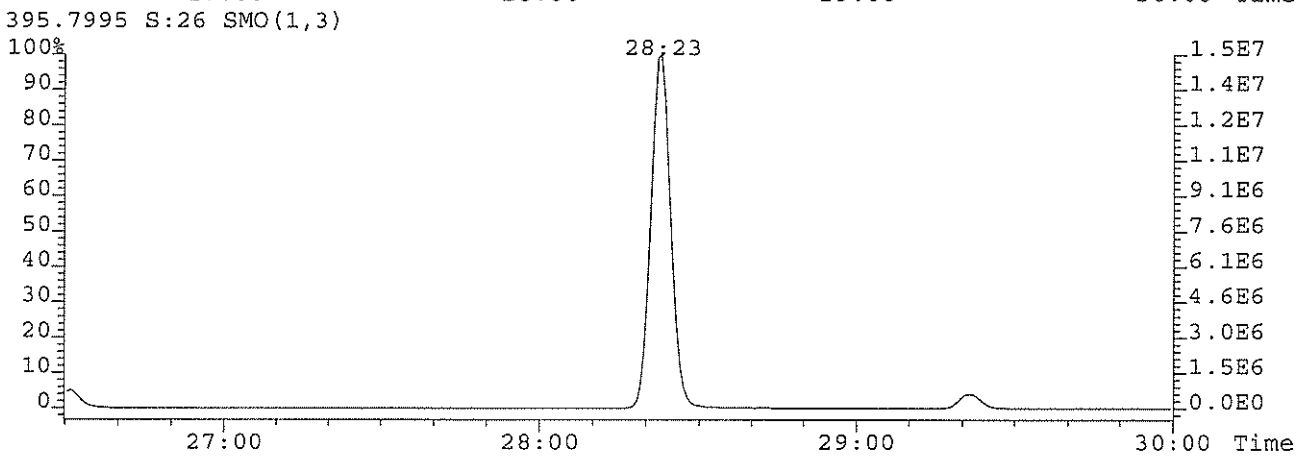
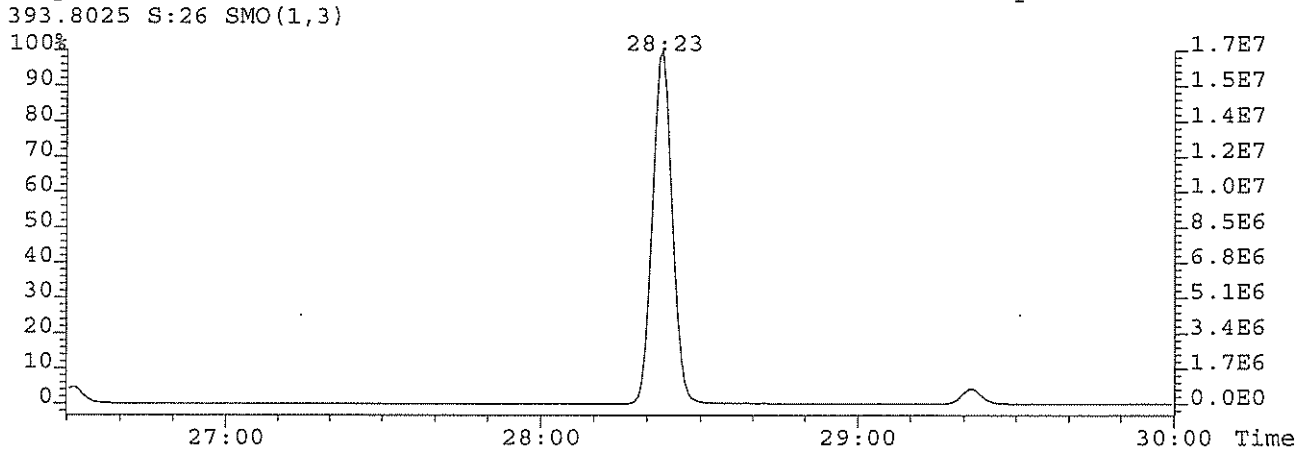


373.8788 S:26 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130713 #1-2897 Acq:14-JUL-2013 05:36:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#26 File Text:RH-12ms(mP) Text:XE13 0957 2 Exp:RH-MP11

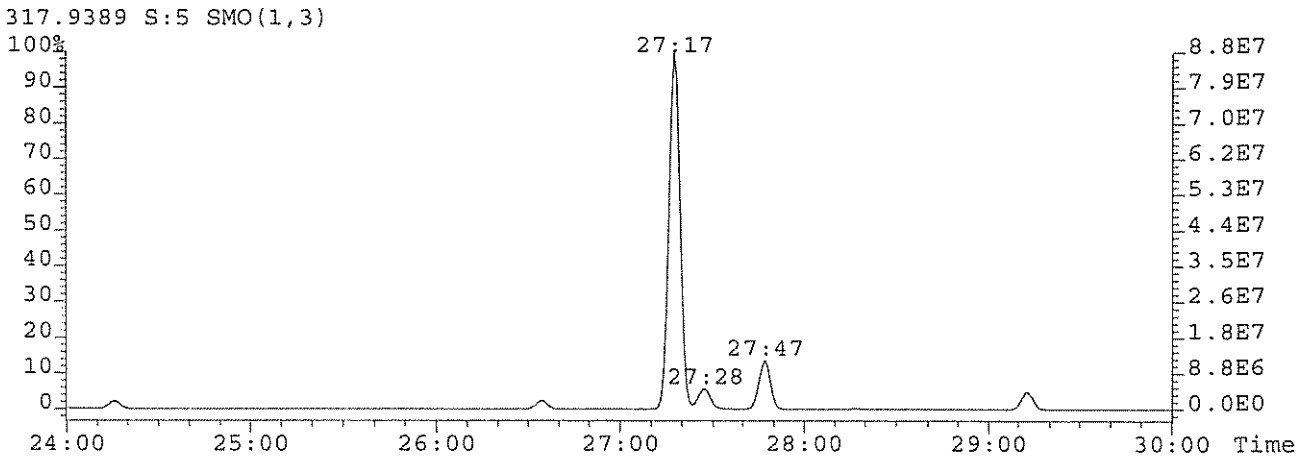
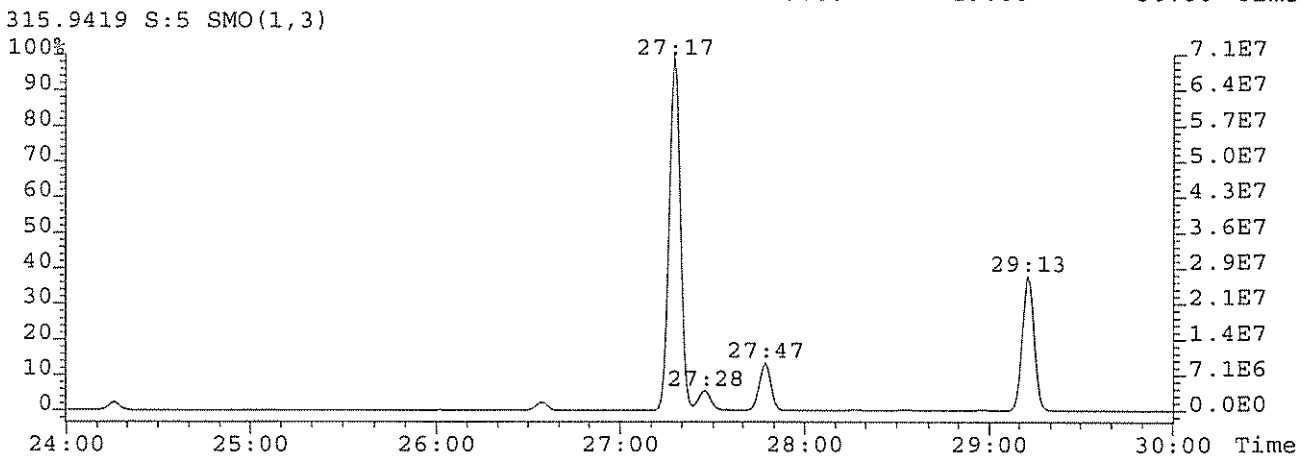
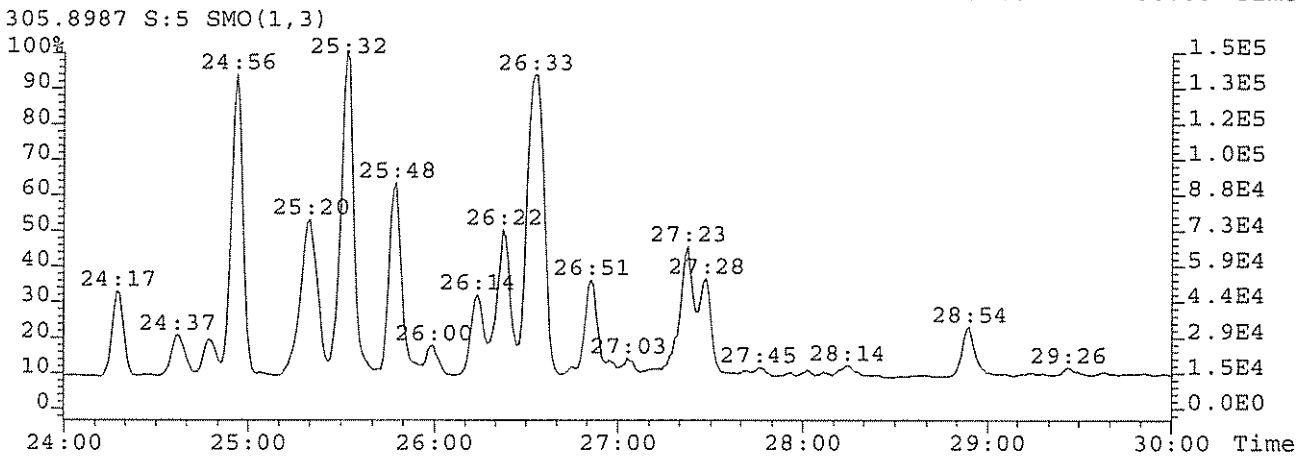
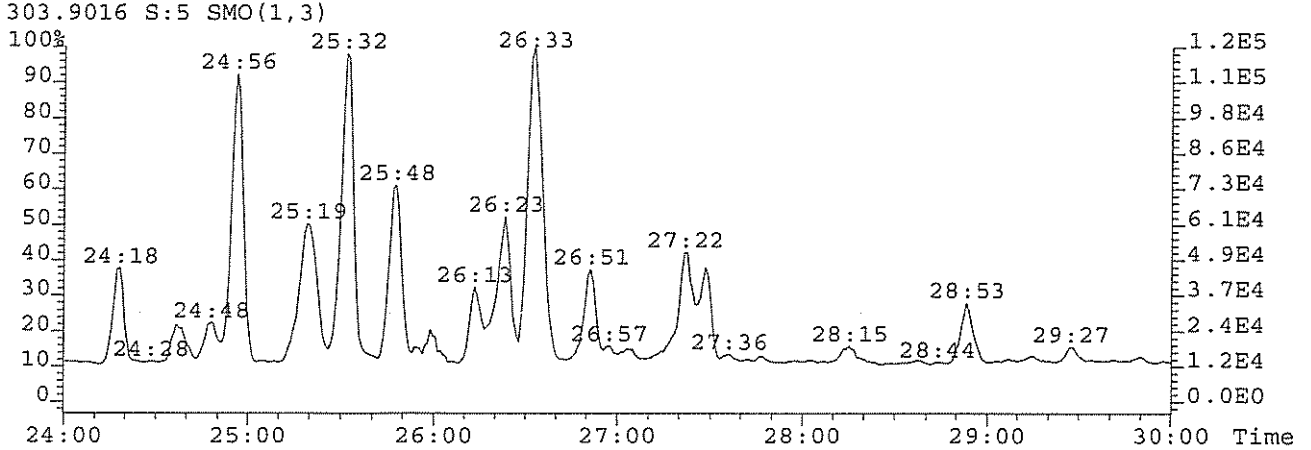


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

試料管理番号	XE 130958
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.12

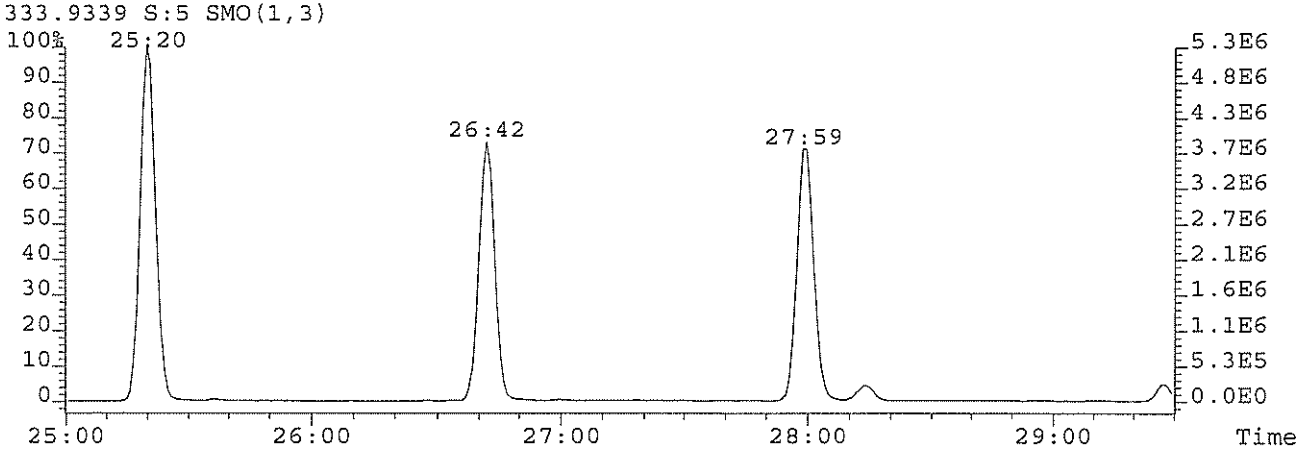
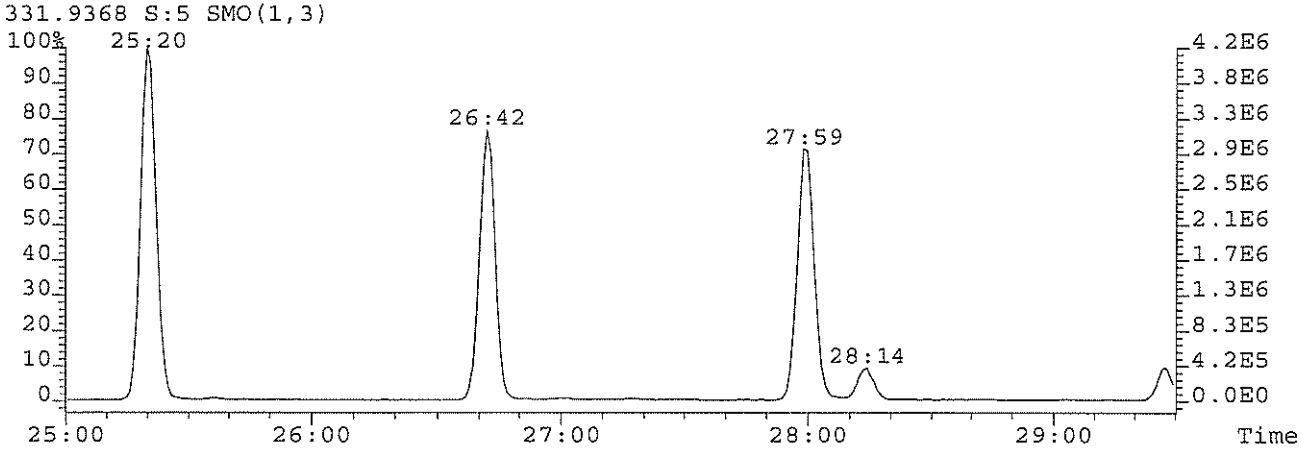
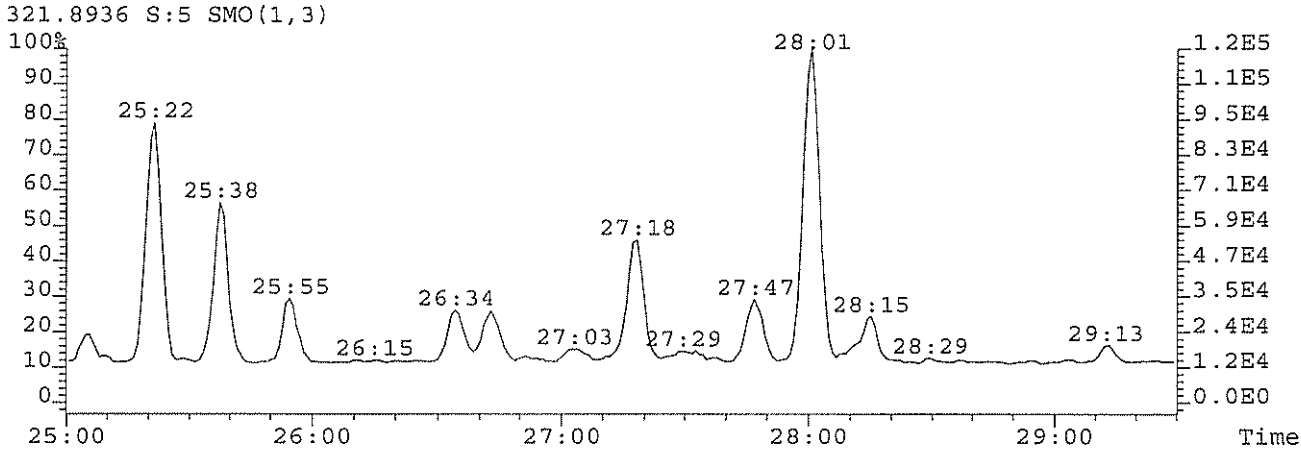
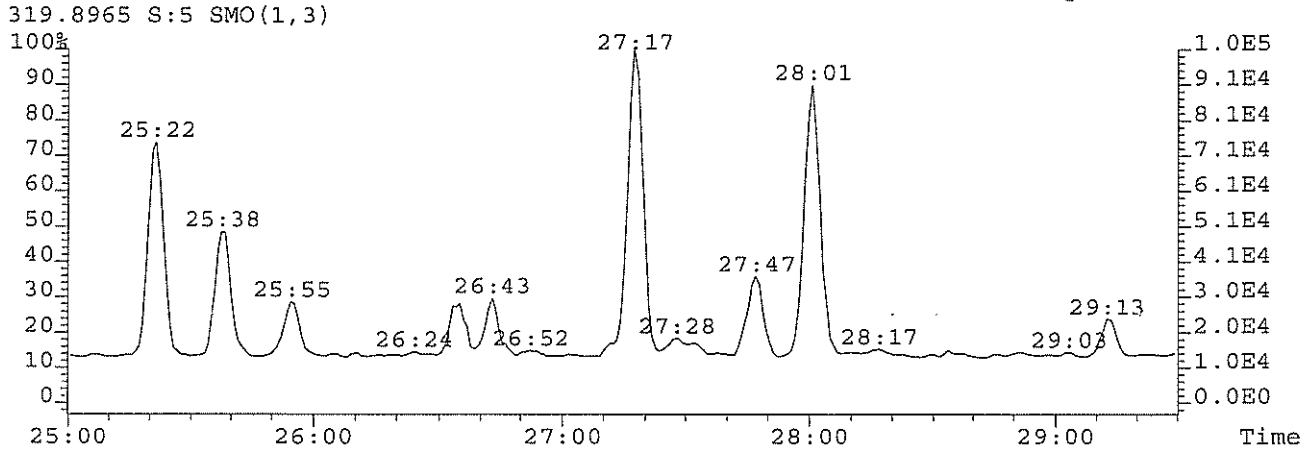


File:130716 #1-2009 Acq:16-JUL-2013 15:47:09 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#5 File Text:BPX-DXN(4-6DXN) Text:XE13 0958 Exp:BPX03



PCDFsクロマトグラム (1)  
(TeCDFs)

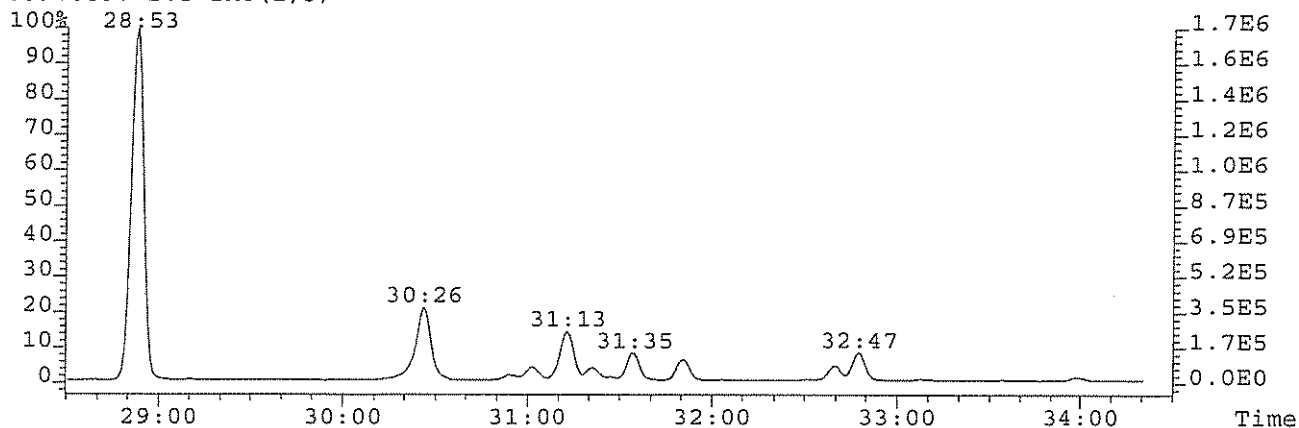
File:130716 #1-2009 Acq:16-JUL-2013 15:47:09 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#5 File Text:BPX-DXN(4-6DXN) Text:XE13 0958 Exp:BPX03



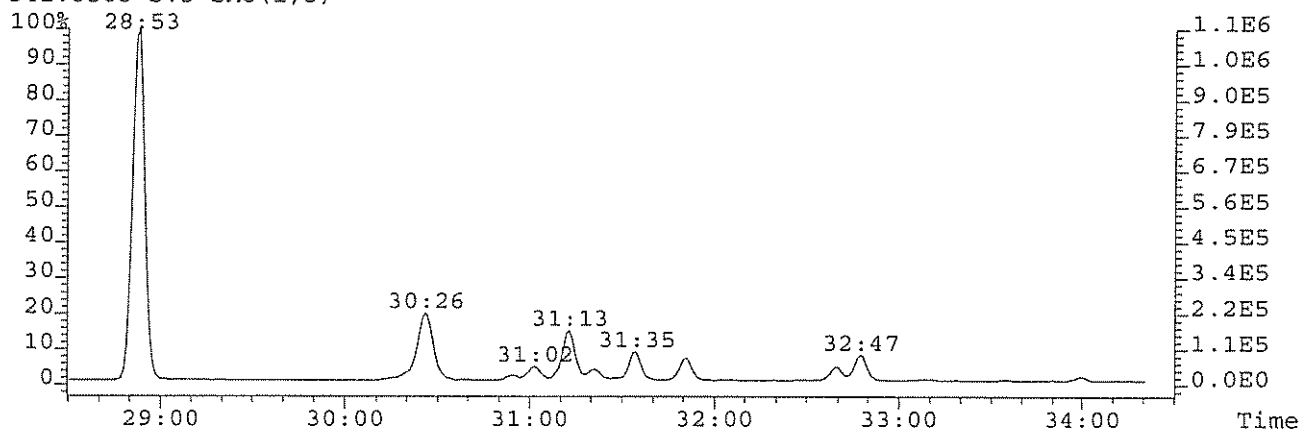
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130716 #1-2009 Acq:16-JUL-2013 15:47:09 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#5 File Text:BPX-DXN(4-6DXN) Text:XE13 0958 Exp:BPX03

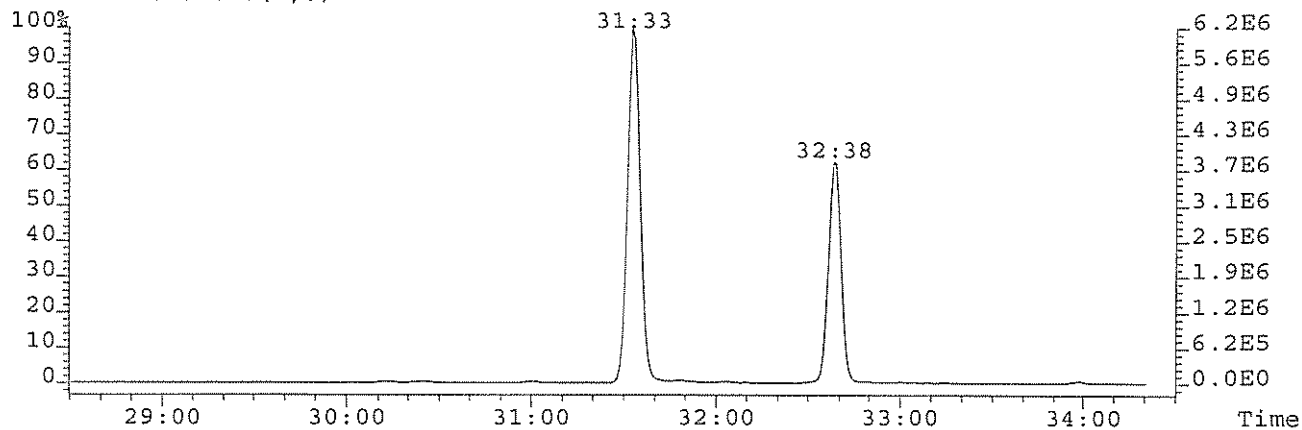
339.8597 S:5 SMO(1,3)



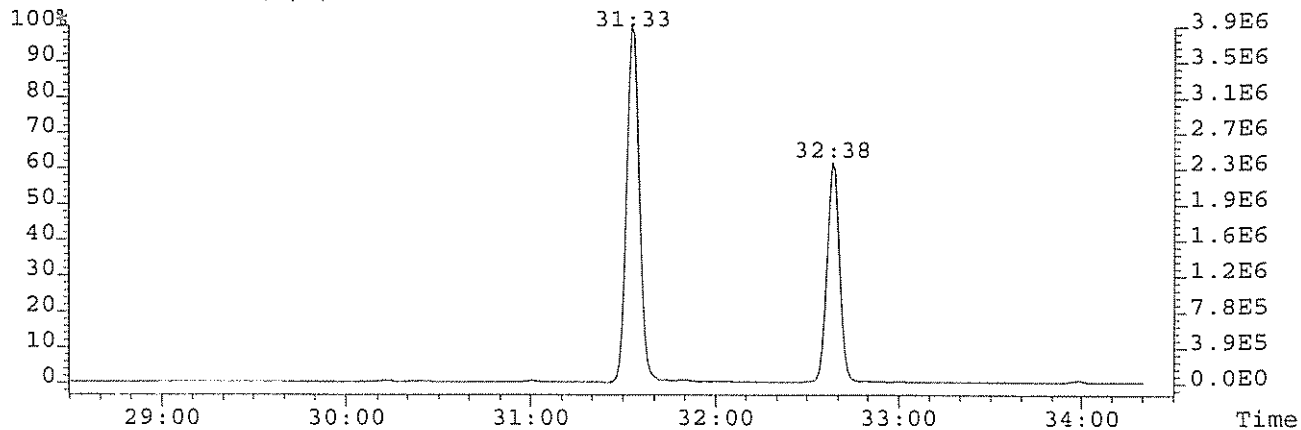
341.8568 S:5 SMO(1,3)



351.9000 S:5 SMO(1,3)

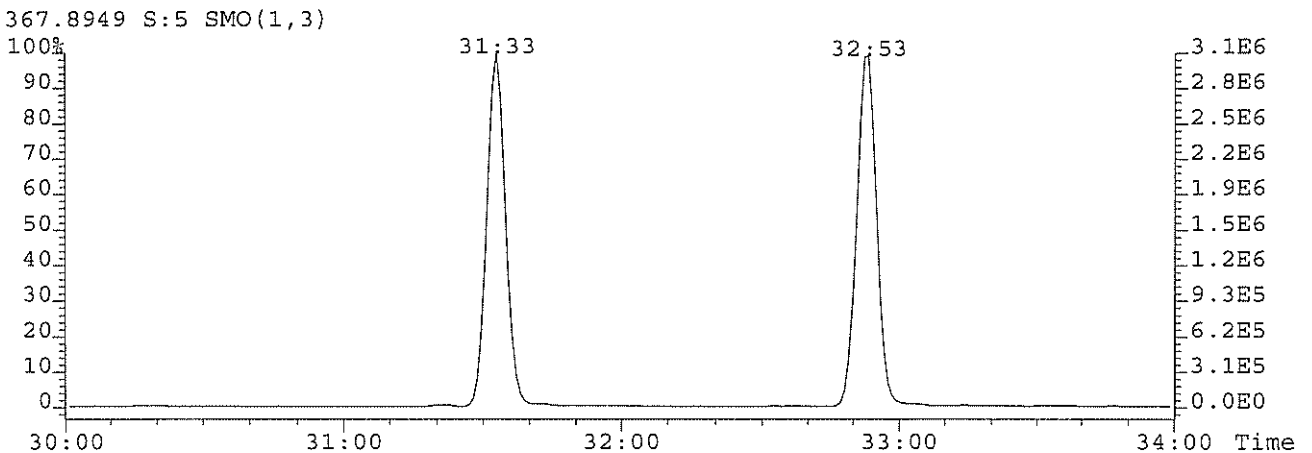
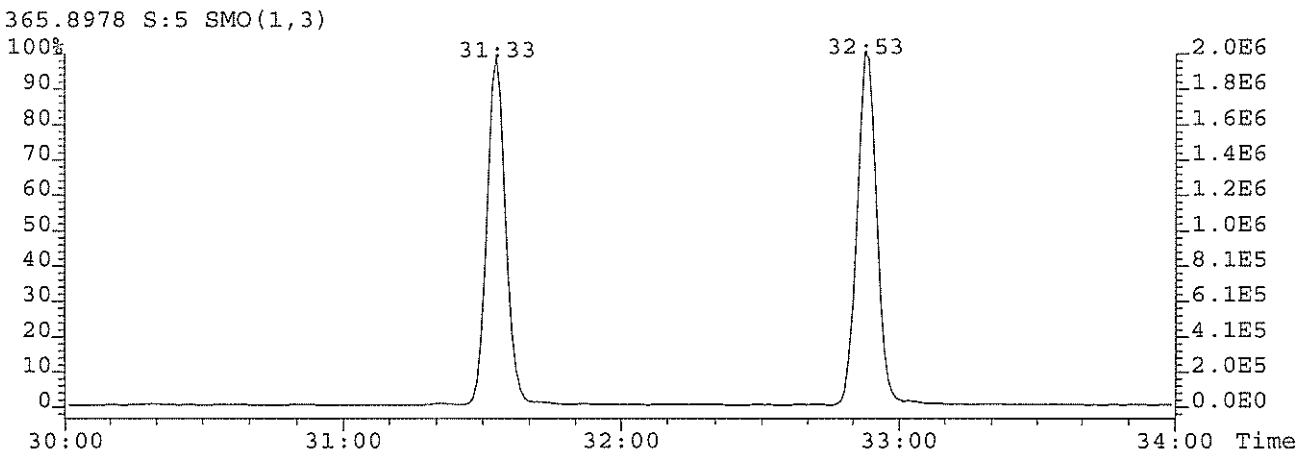
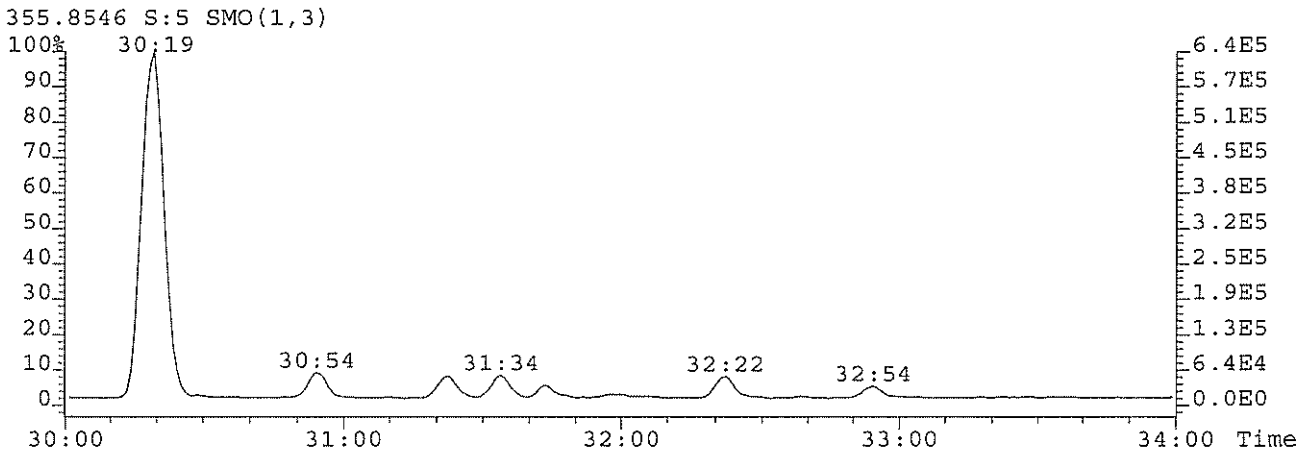
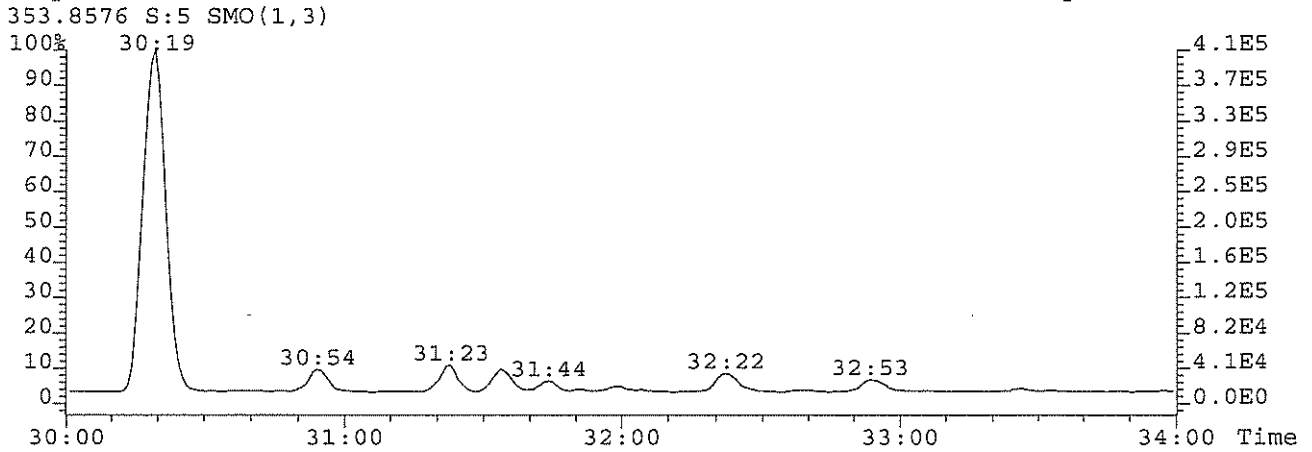


353.8970 S:5 SMO(1,3)



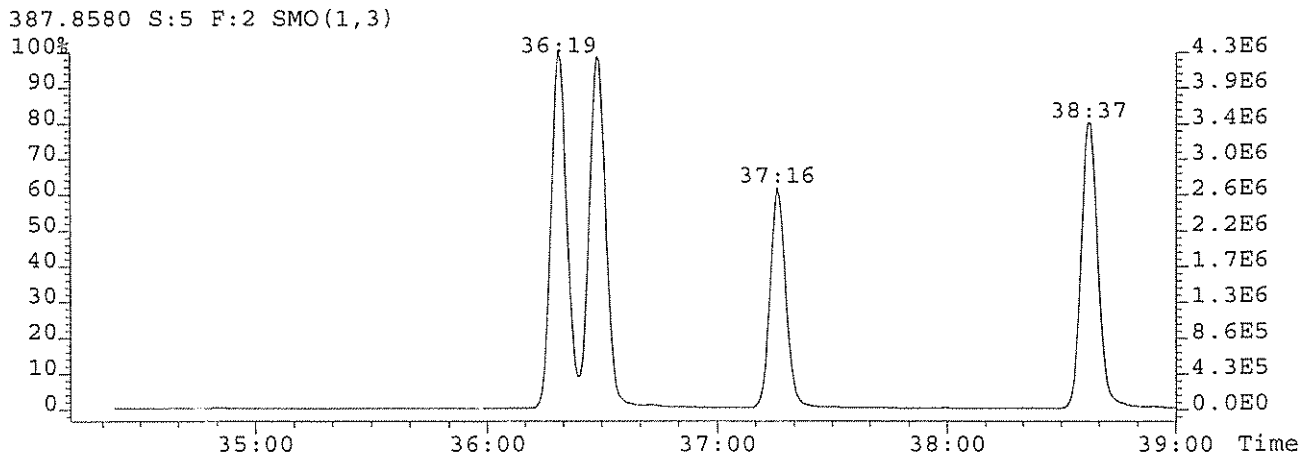
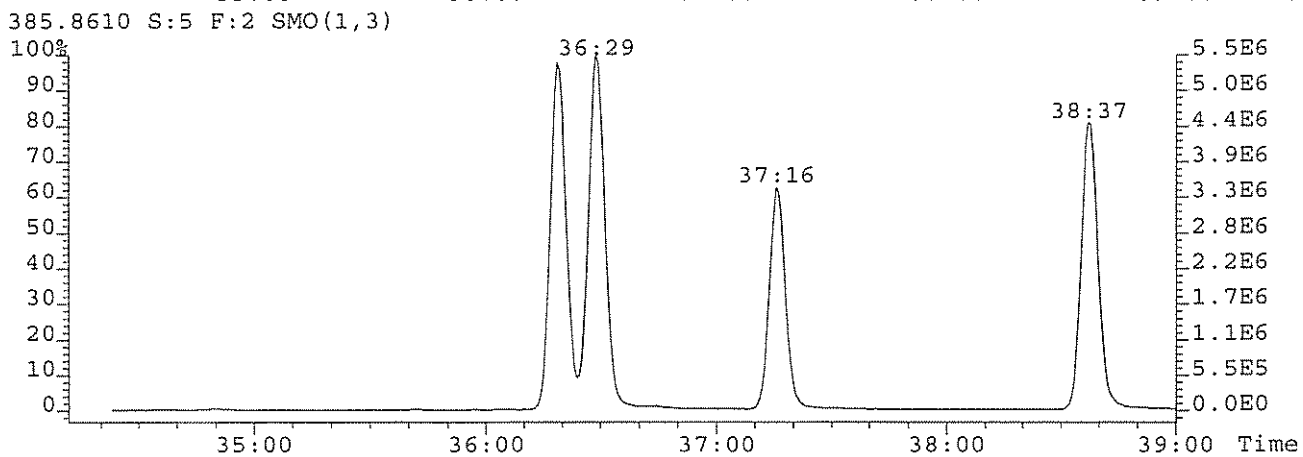
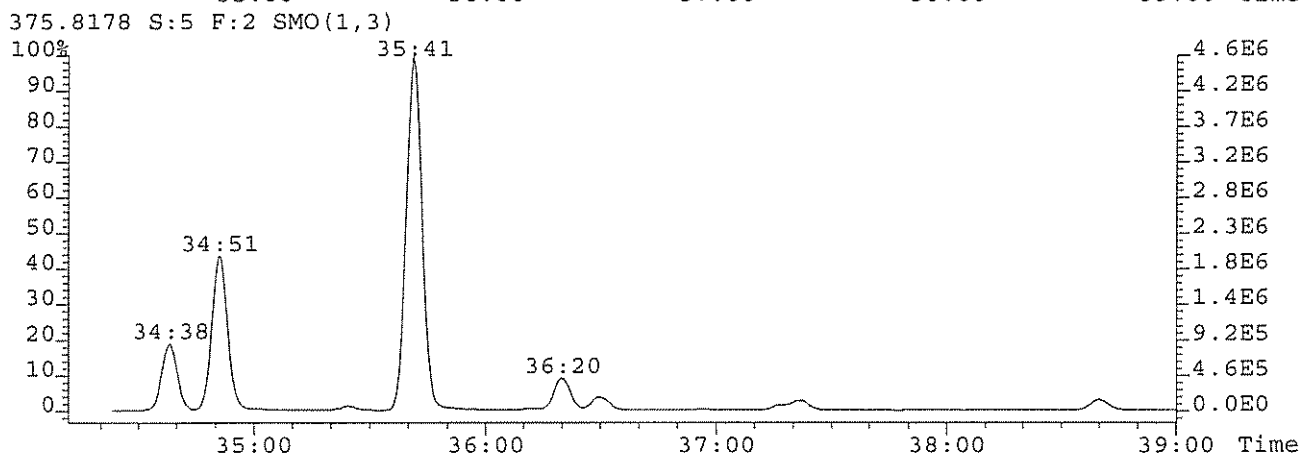
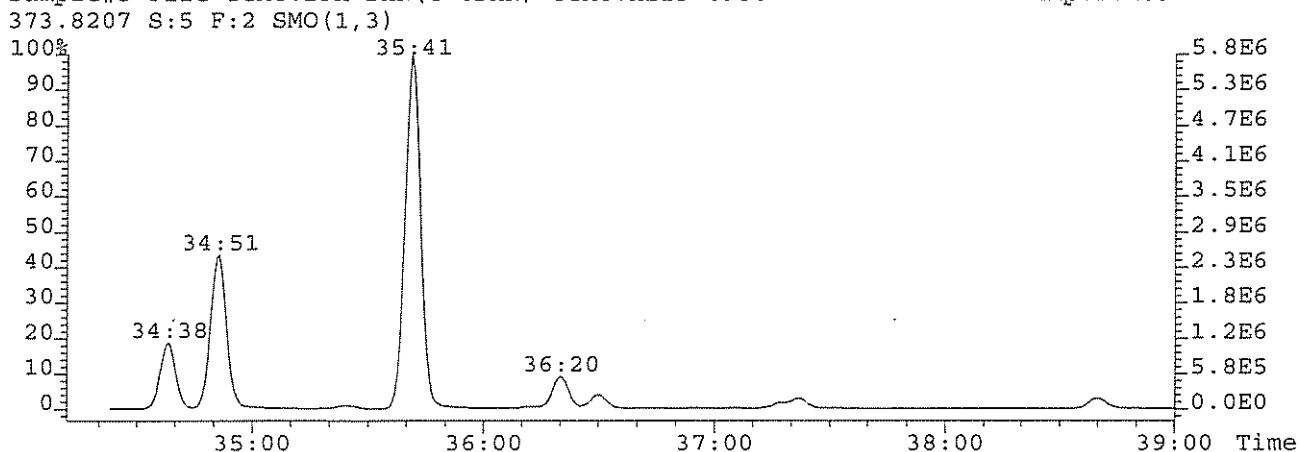
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130716 #1-2009 Acq:16-JUL-2013 15:47:09 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#5 File Text:BPX-DXN(4-6DXN) Text:XE13 0958 Exp:BPX03



PCDDsクロマトグラム (4)  
(PeCDDs)

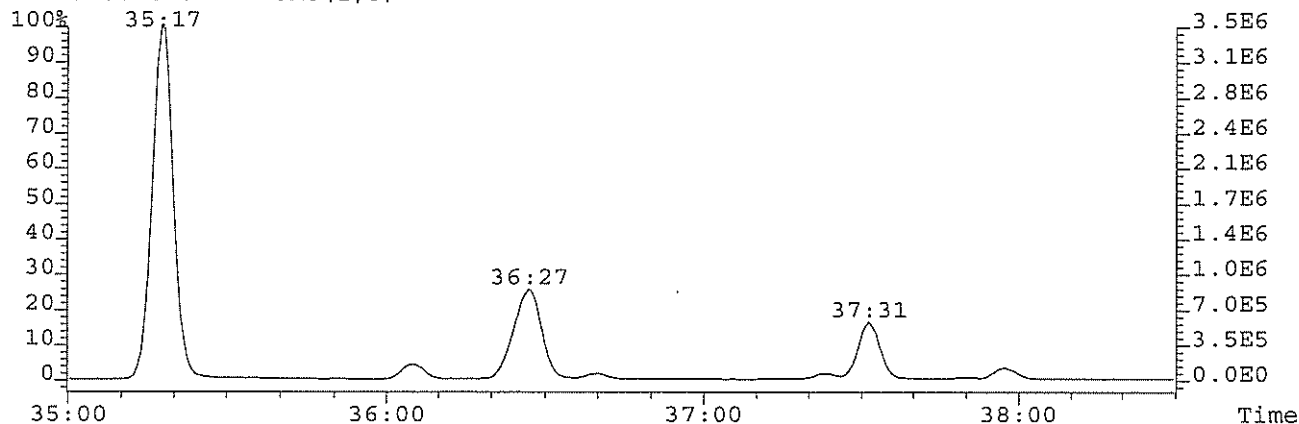
File:130716 #1-1955 Acq:16-JUL-2013 15:47:09 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#5 File Text:BPX-DXN(4-6DXN) Text:XE13 0958 Exp:BPX03



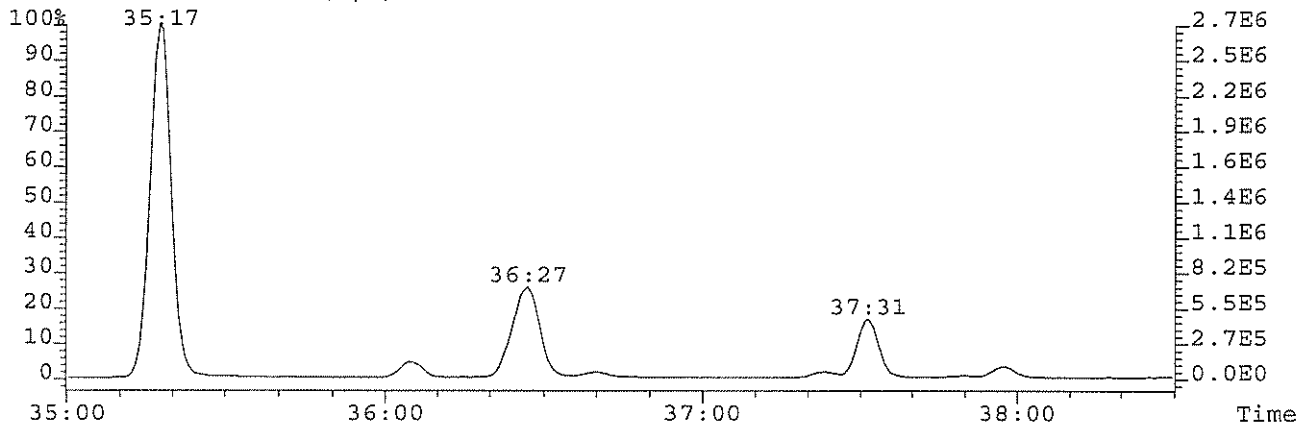
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130716 #1-1955 Acq:16-JUL-2013 15:47:09 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#5 File Text:BPX-DXN(4-6DXN) Text:XE13 0958 Exp:BPX03

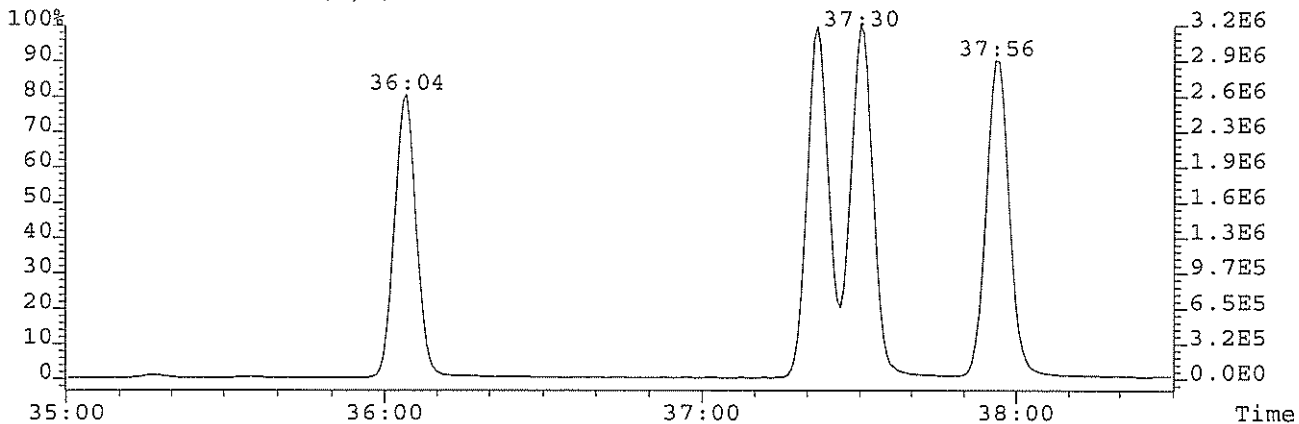
389.8156 S:5 F:2 SMO(1,3)



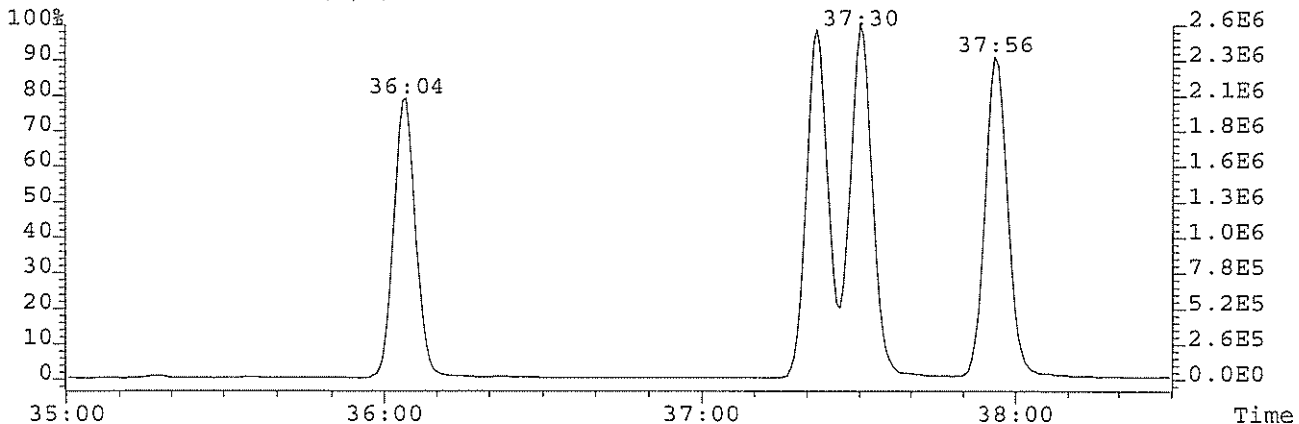
391.8127 S:5 F:2 SMO(1,3)



401.8559 S:5 F:2 SMO(1,3)

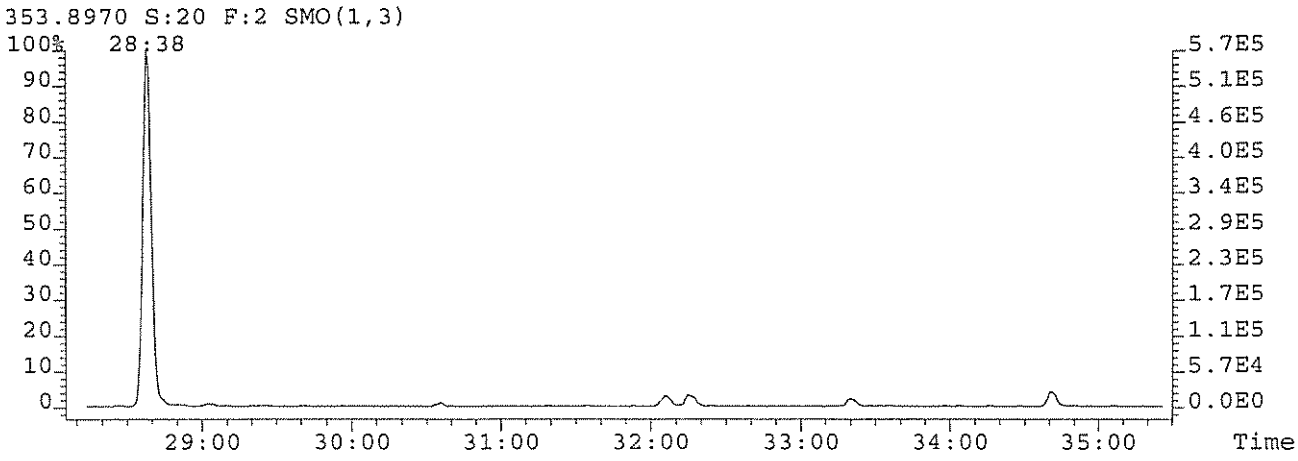
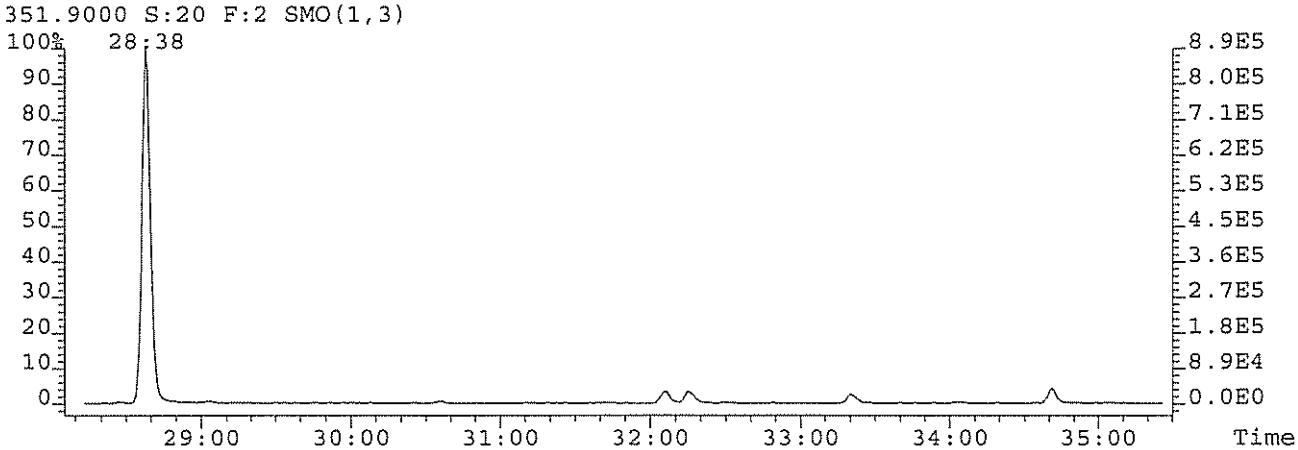
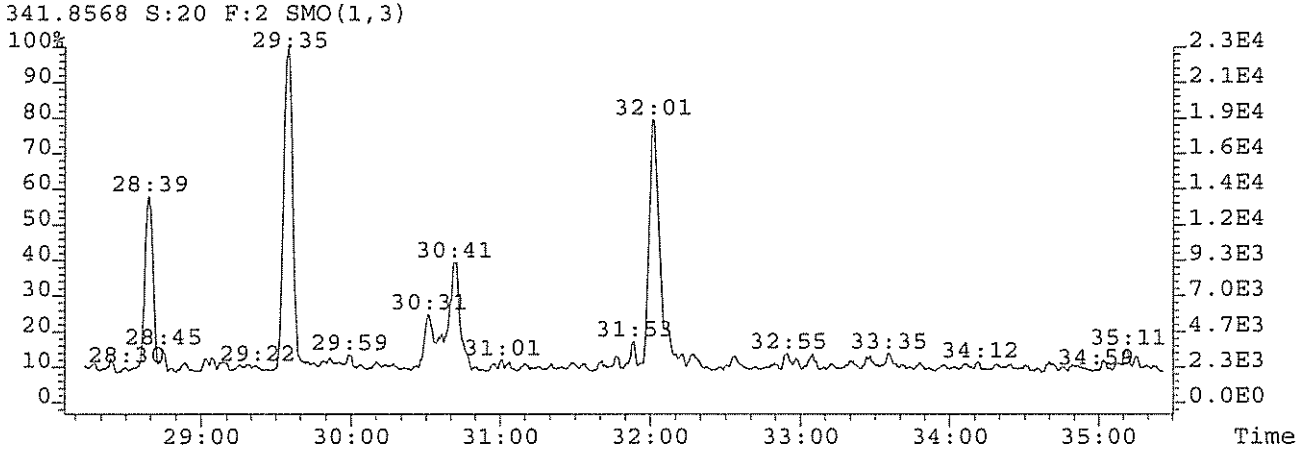
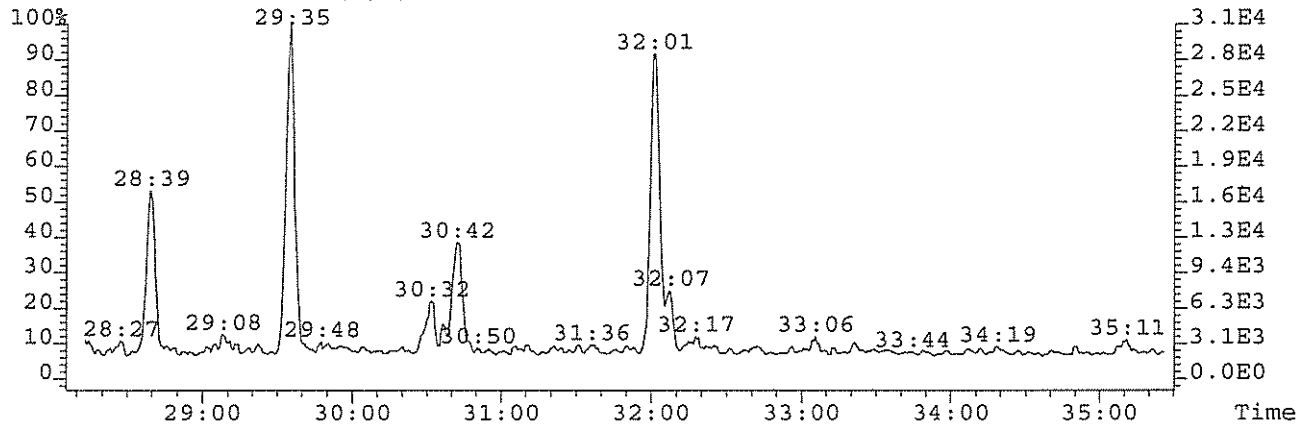


403.8530 S:5 F:2 SMO(1,3)



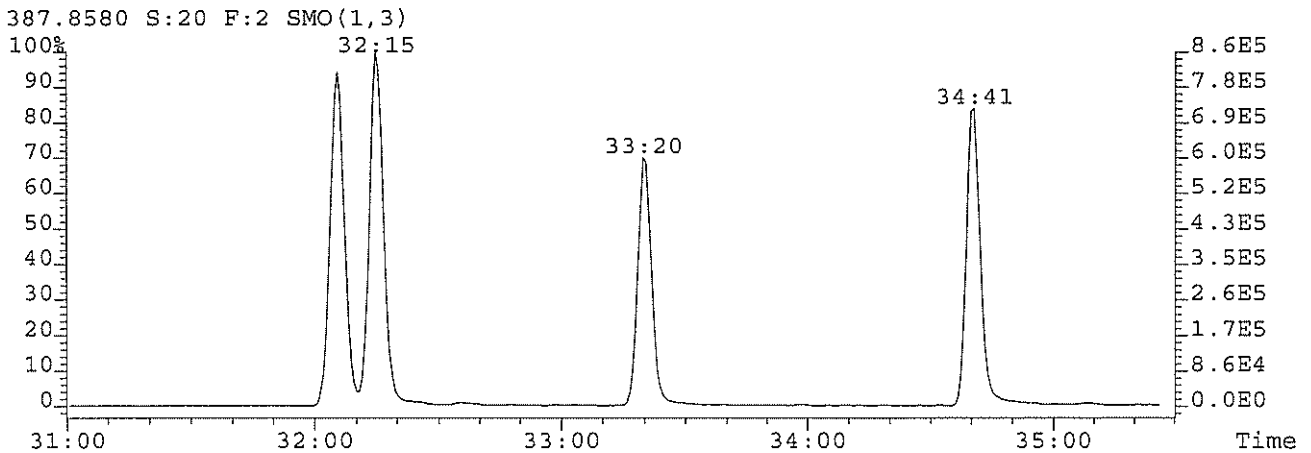
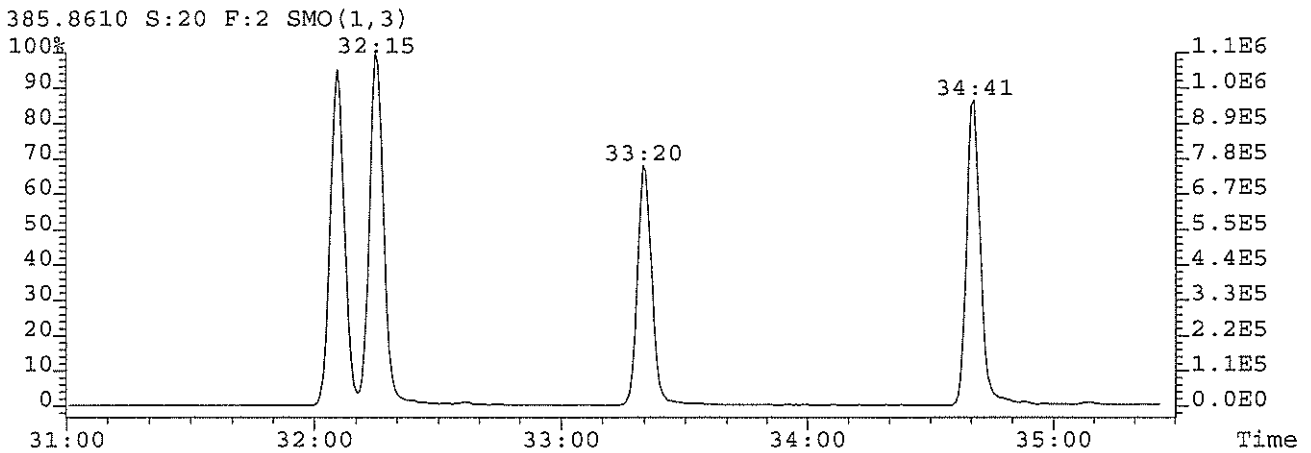
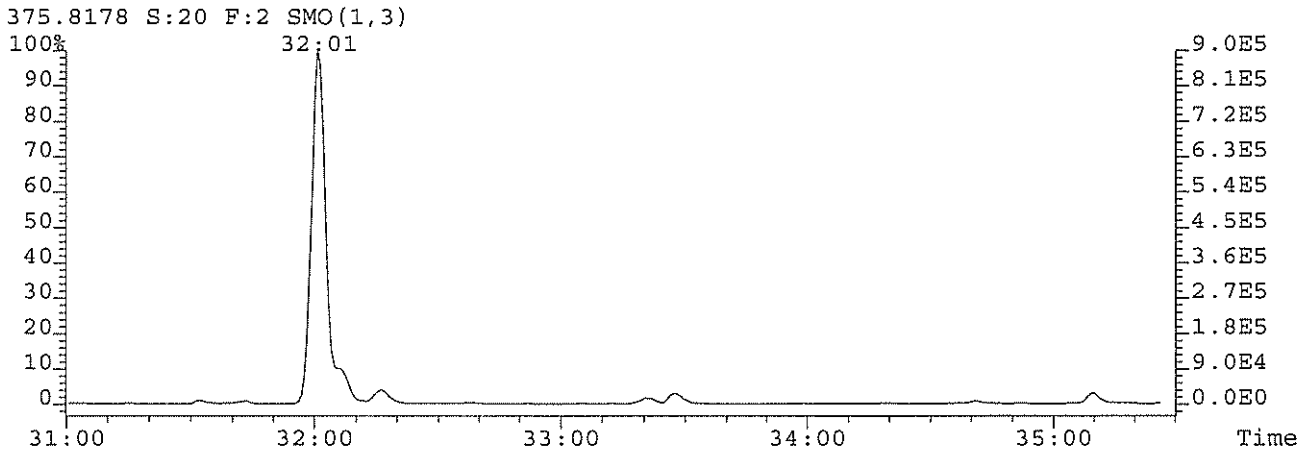
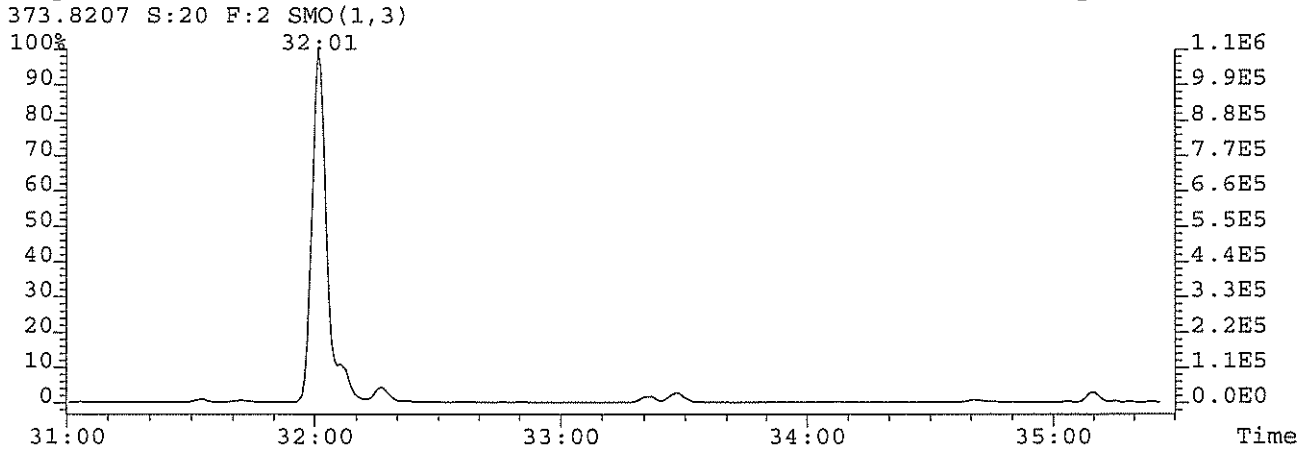
PCDDsクロマトグラム (6)  
(HxCDDs)

File:130711-2 #1-648 Acq:12-JUL-2013 10:32:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0958 3 Exp:RH-PD22  
339.8597 S:20 F:2 SMO(1,3)



PeCDFsクロマトグラム (7)  
(23478-PeCDF)

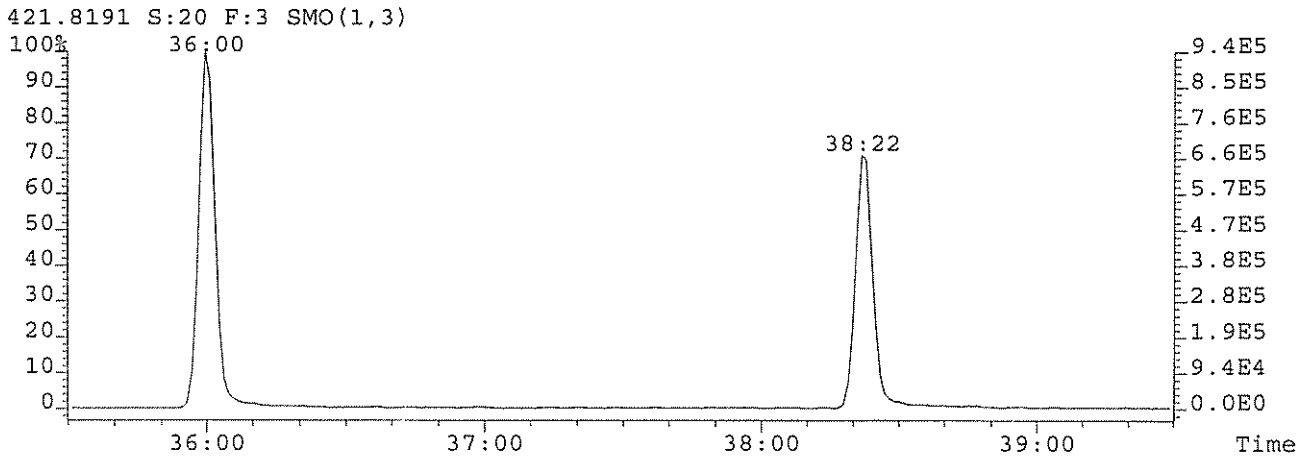
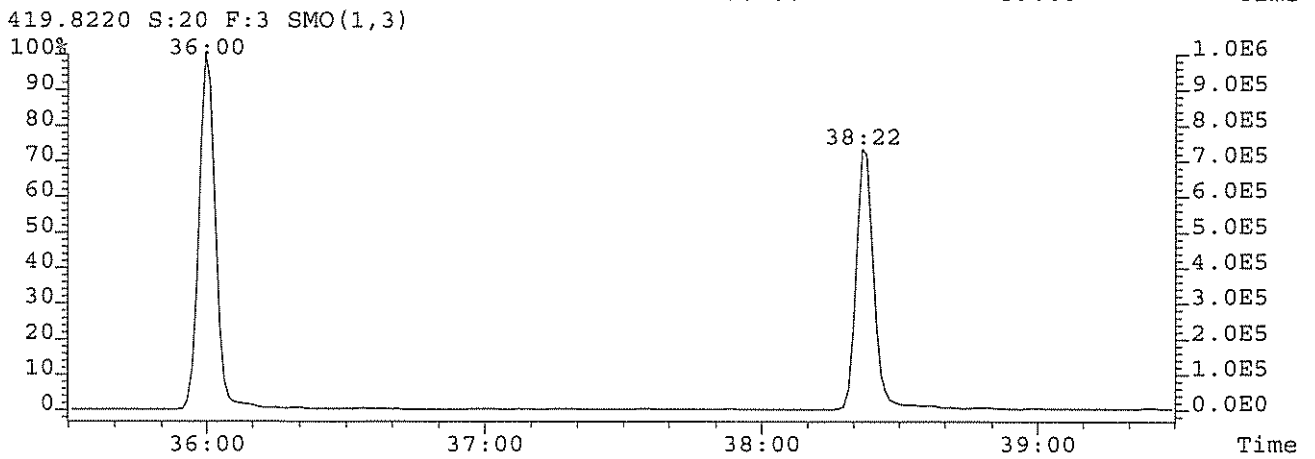
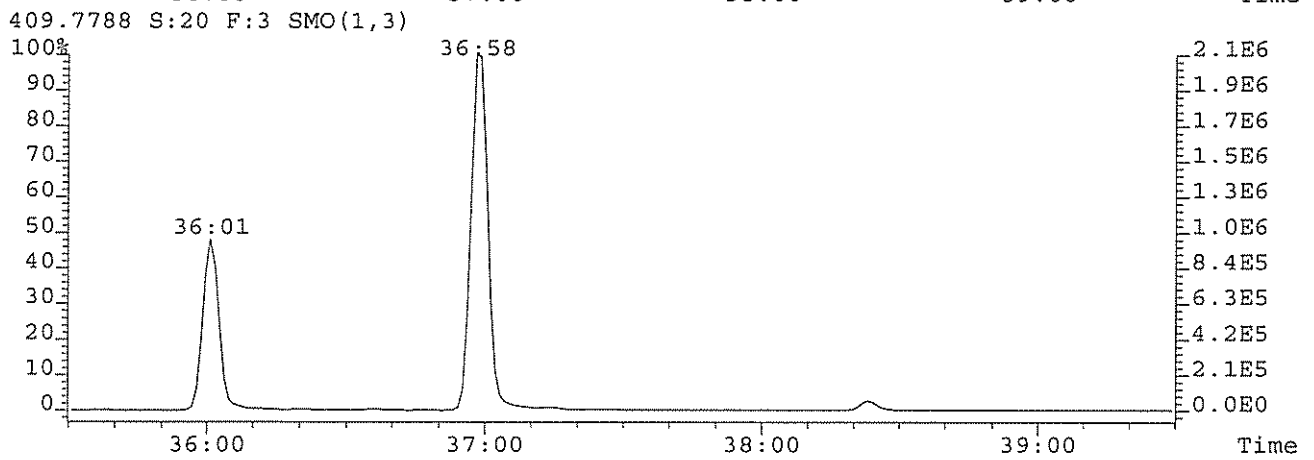
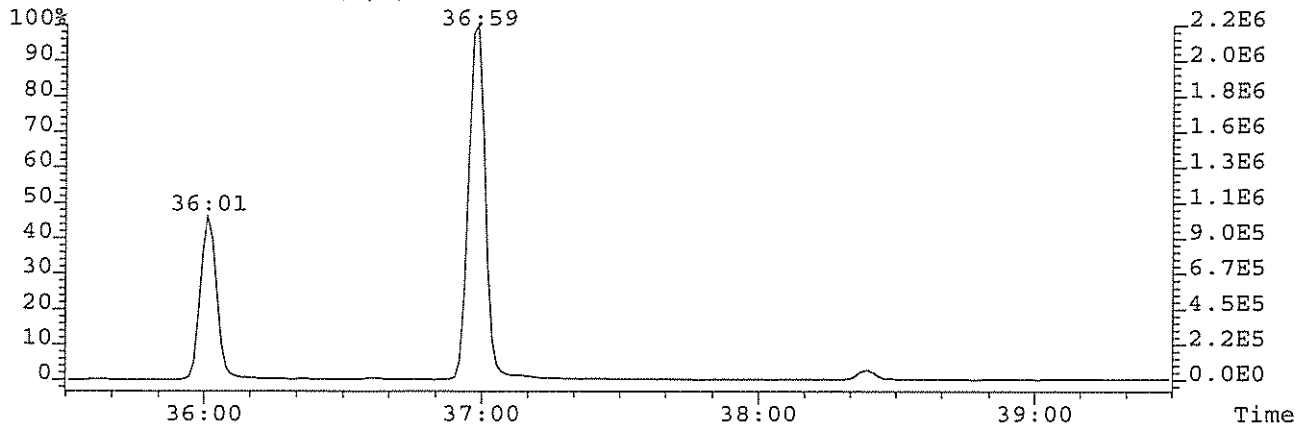
File:130711-2 #1-648 Acq:12-JUL-2013 10:32:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0958 3 Exp:RH-PD22



HxCDFsクロマトグラム (8)  
(123789-HxCDF)



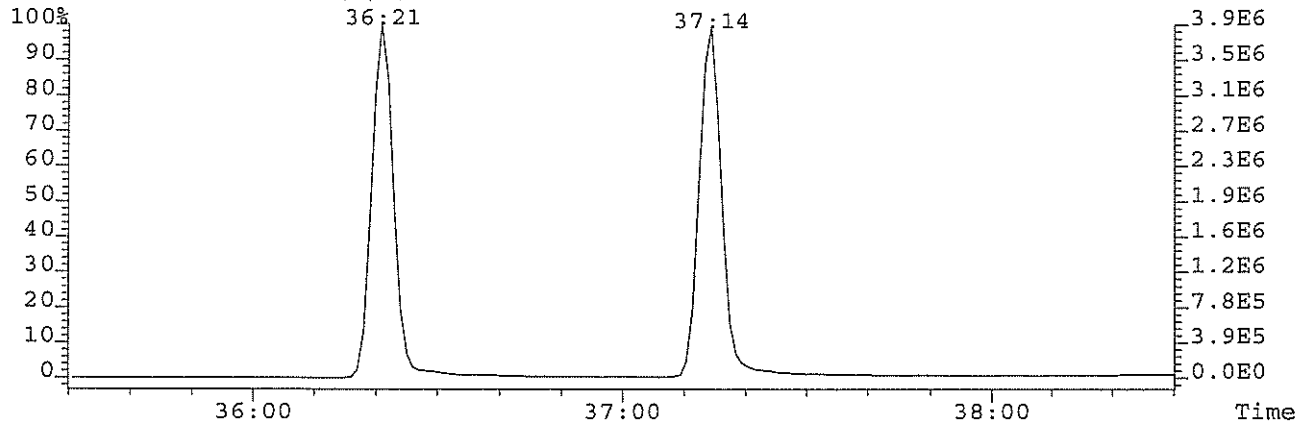
File:130711-2 #1-561 Acq:12-JUL-2013 10:32:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0958 3 Exp:RH-PD22  
407.7818 S:20 F:3 SMO(1,3)



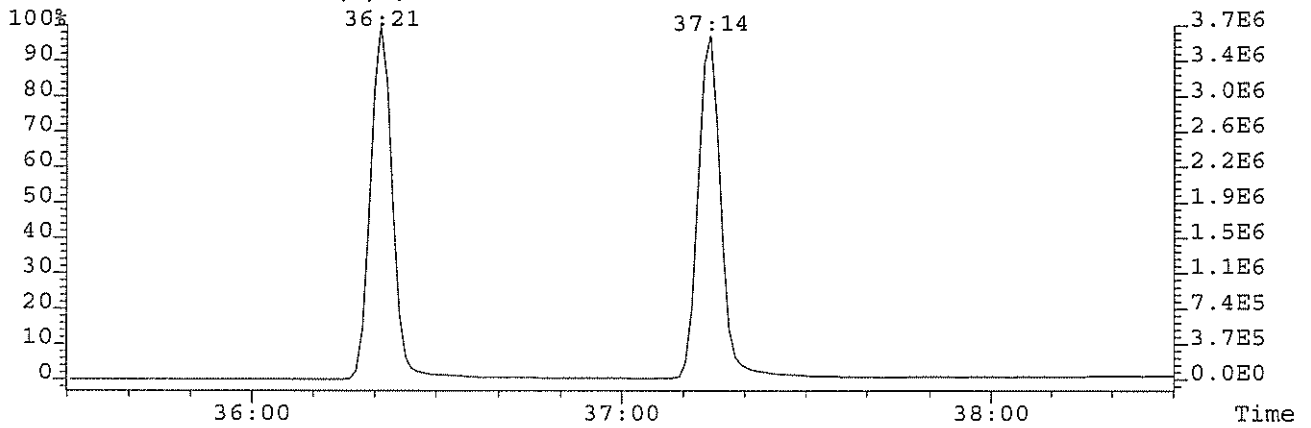
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130711-2 #1-561 Acq:12-JUL-2013 10:32:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0958 3 Exp:RH-PD22

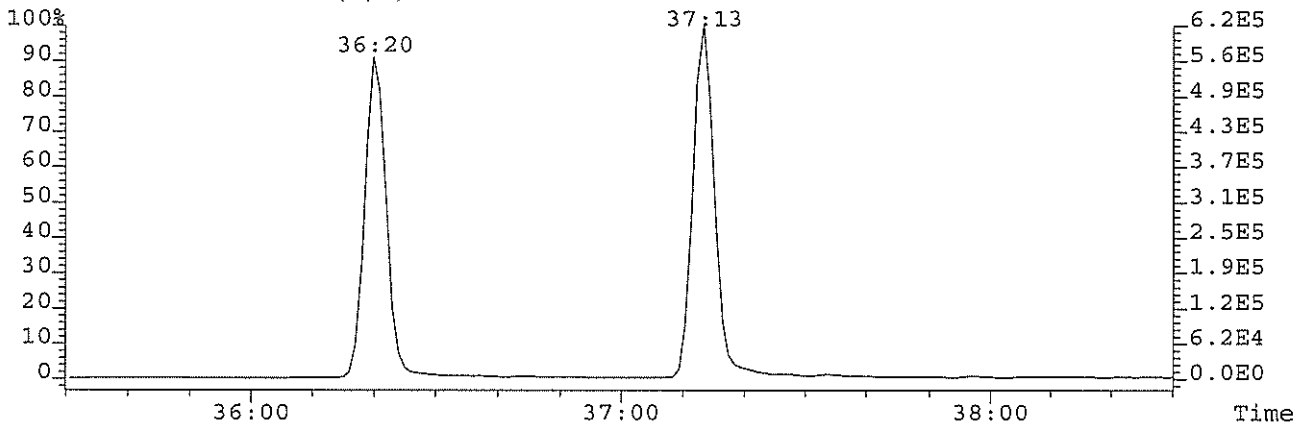
423.7767 S:20 F:3 SMO(1,3)



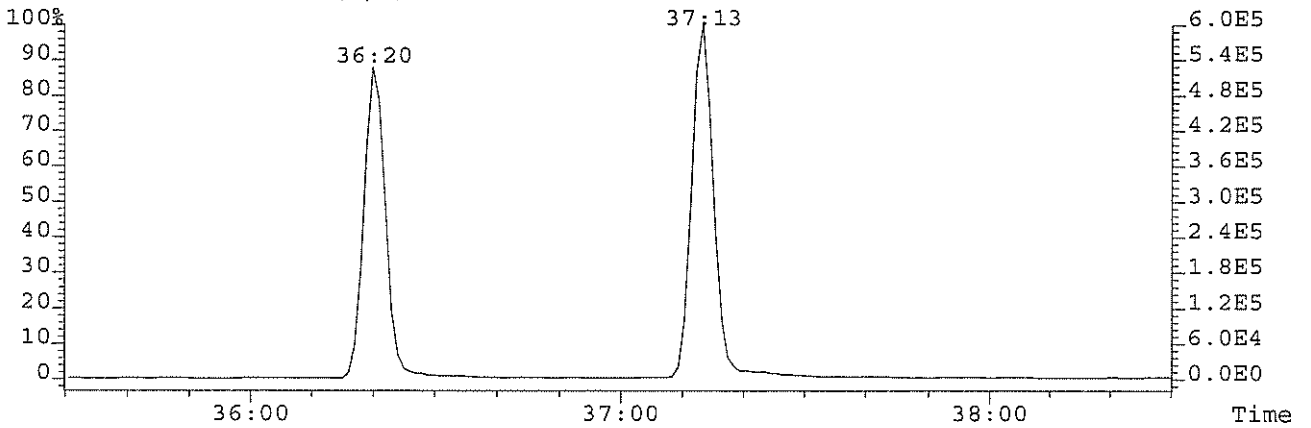
425.7737 S:20 F:3 SMO(1,3)



435.8169 S:20 F:3 SMO(1,3)



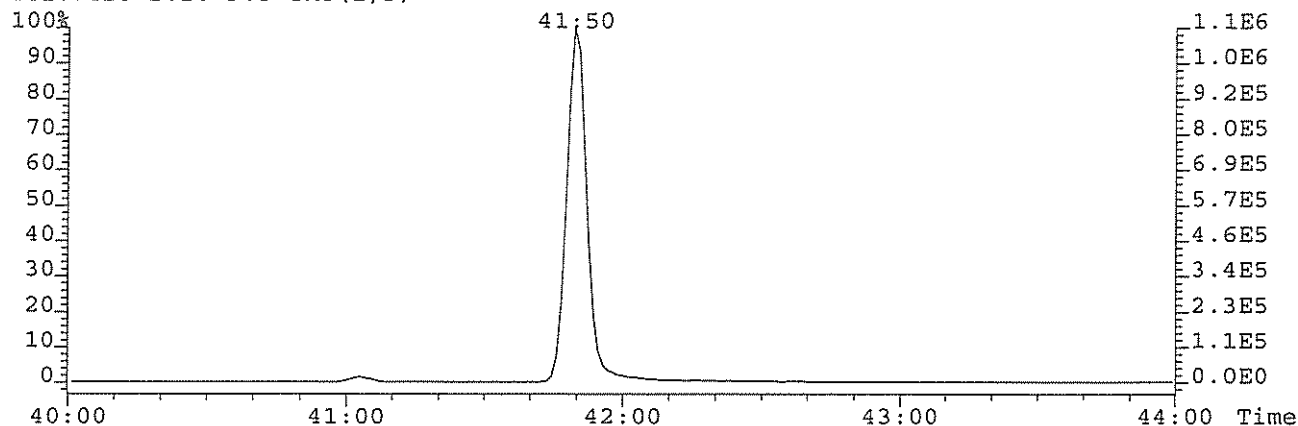
437.8140 S:20 F:3 SMO(1,3)



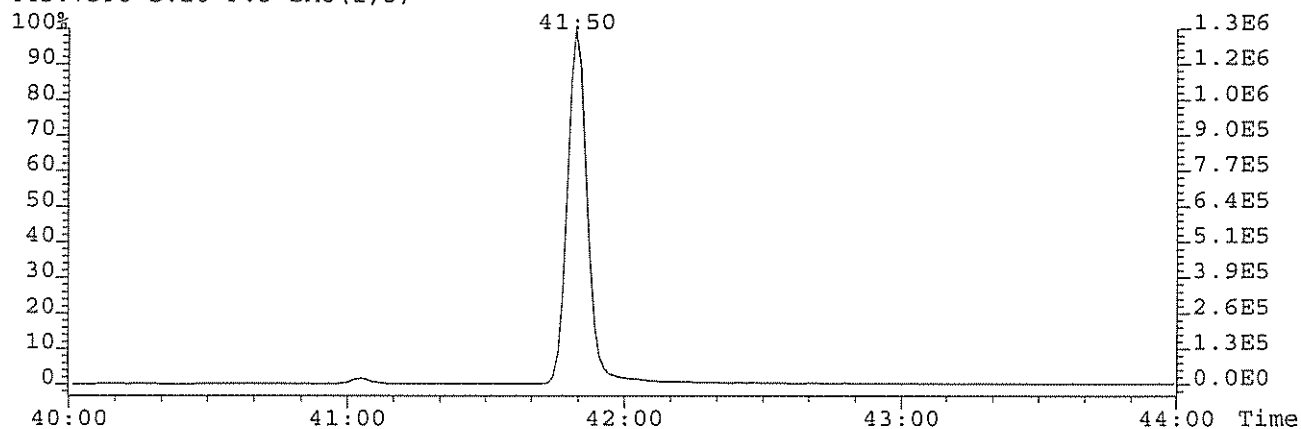
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130711-2 #1-561 Acq:12-JUL-2013 10:32:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0958 3 Exp:RH-PD22

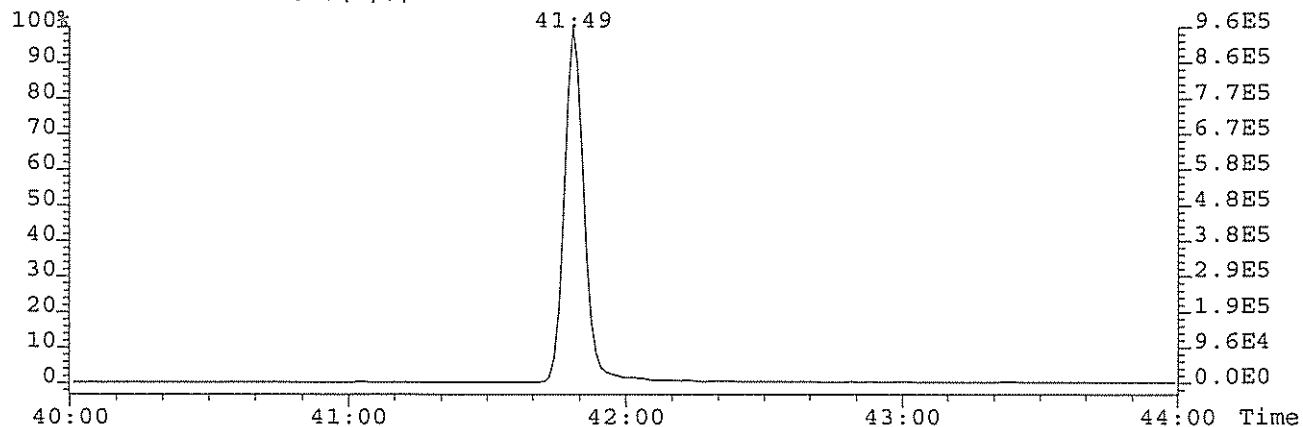
441.7428 S:20 F:3 SMO(1,3)



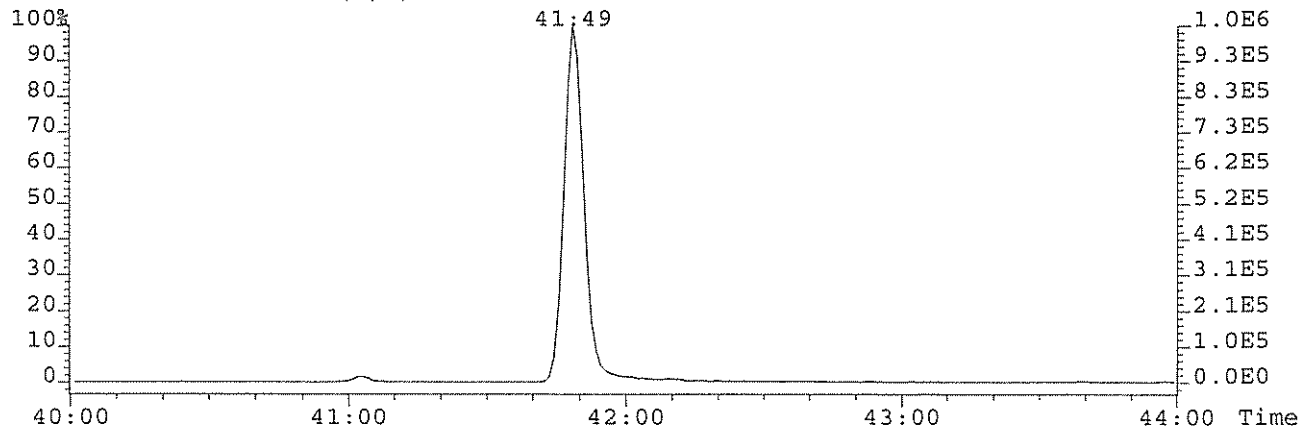
443.7398 S:20 F:3 SMO(1,3)



453.7830 S:20 F:3 SMO(1,3)

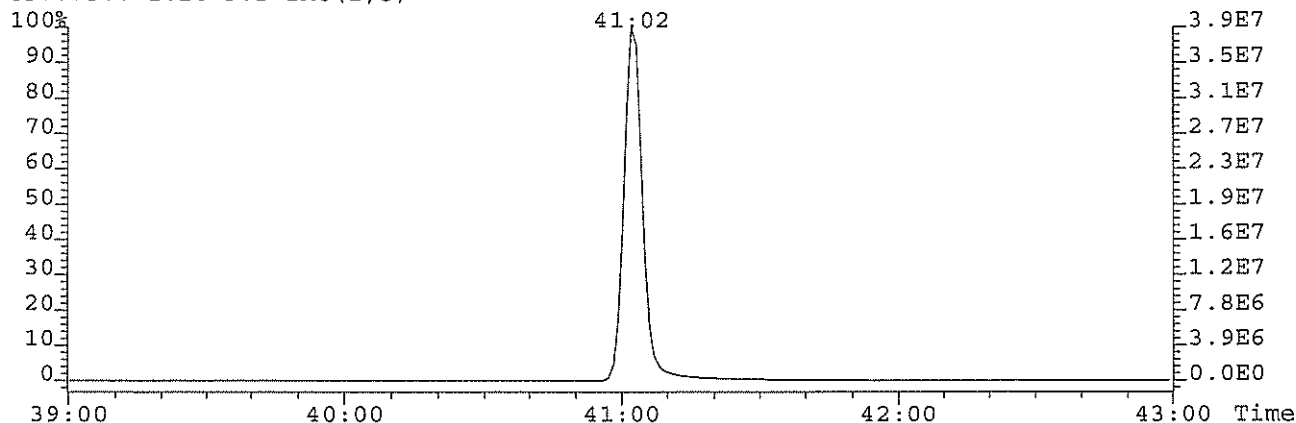


455.7801 S:20 F:3 SMO(1,3)

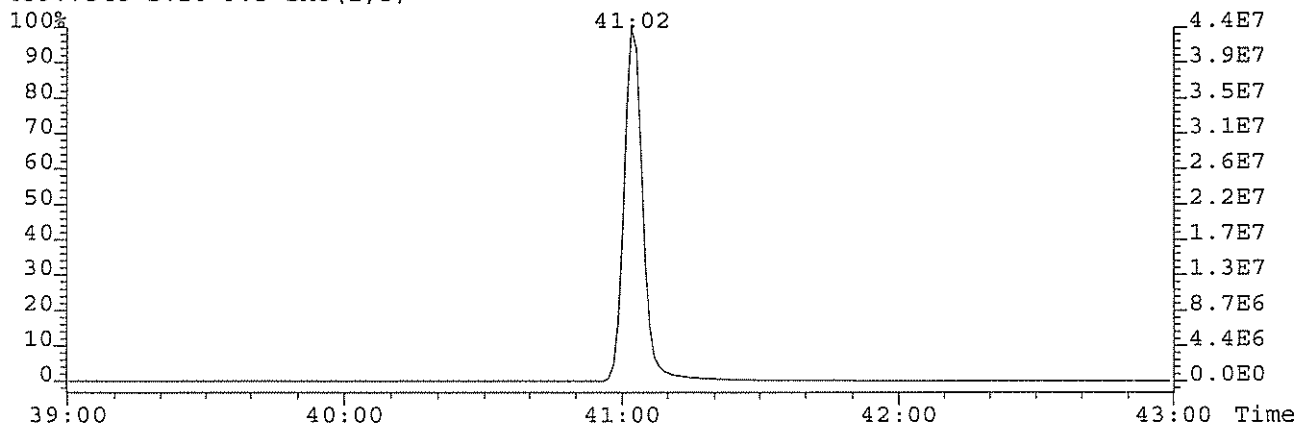


File:130711-2 #1-561 Acq:12-JUL-2013 10:32:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0958 3 Exp:RH-PD22

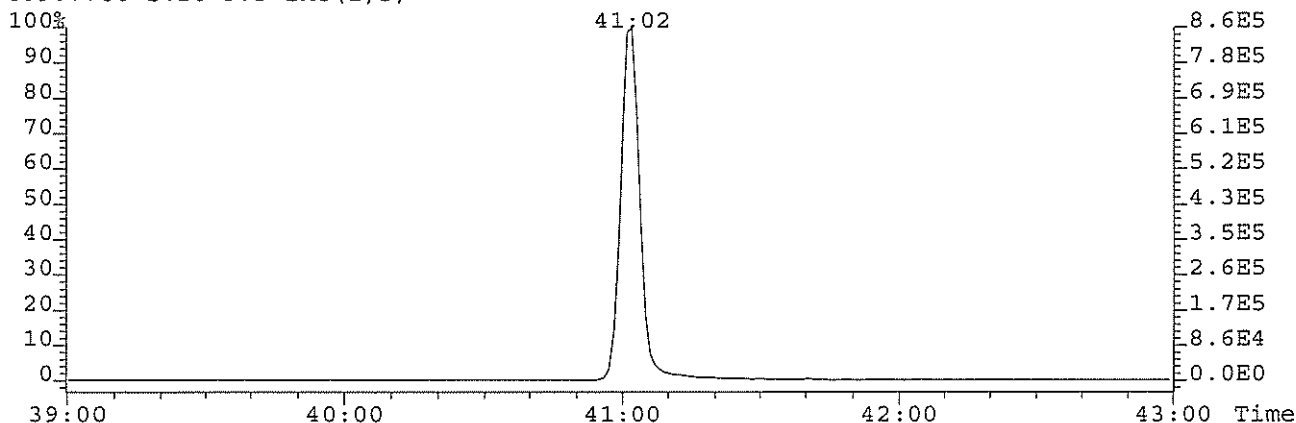
457.7377 S:20 F:3 SMO(1,3)



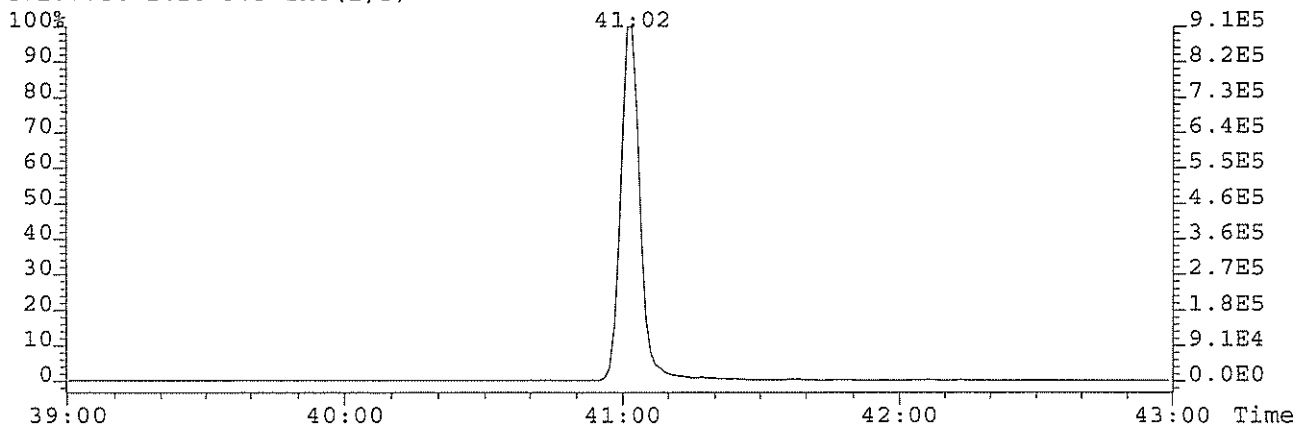
459.7348 S:20 F:3 SMO(1,3)



469.7780 S:20 F:3 SMO(1,3)

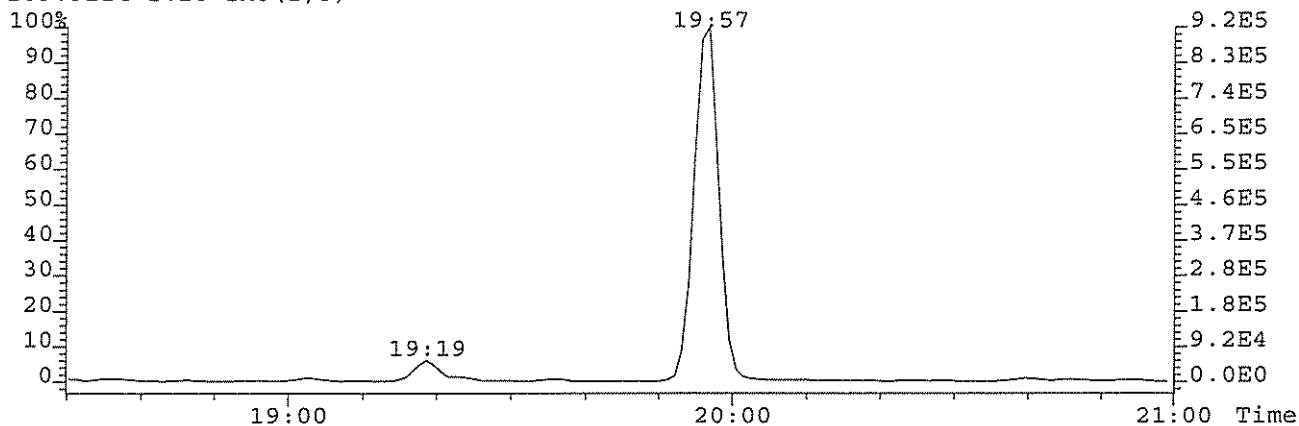


471.7750 S:20 F:3 SMO(1,3)

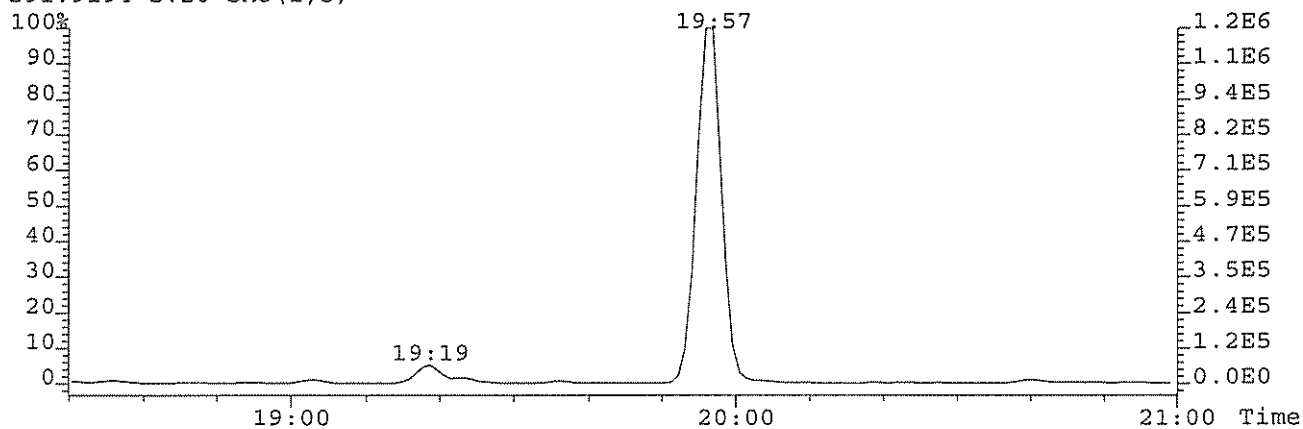


File:130711-2 #1-1430 Acq:12-JUL-2013 10:32:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0958 3 Exp:RH-PD22

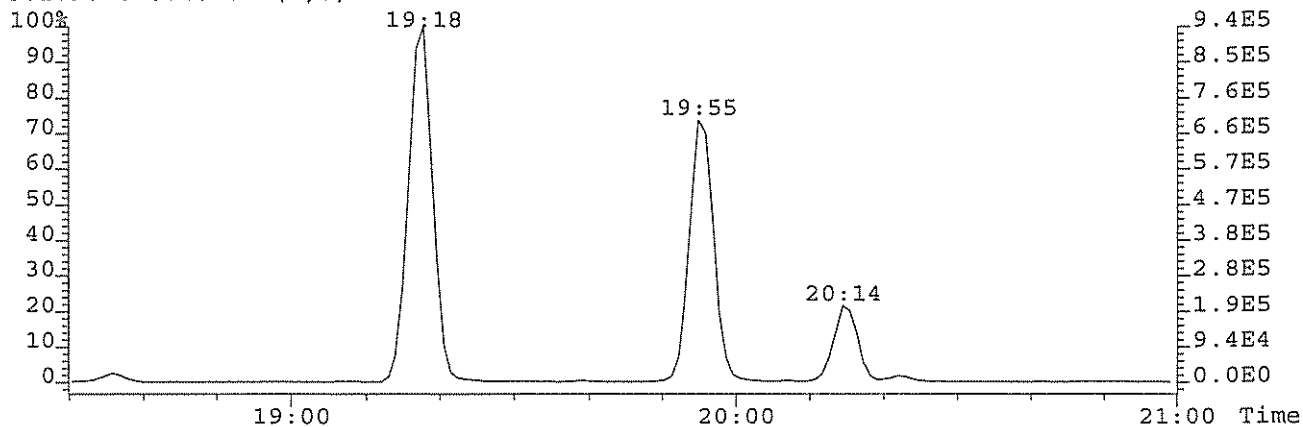
289.9224 S:20 SMO(1,3)



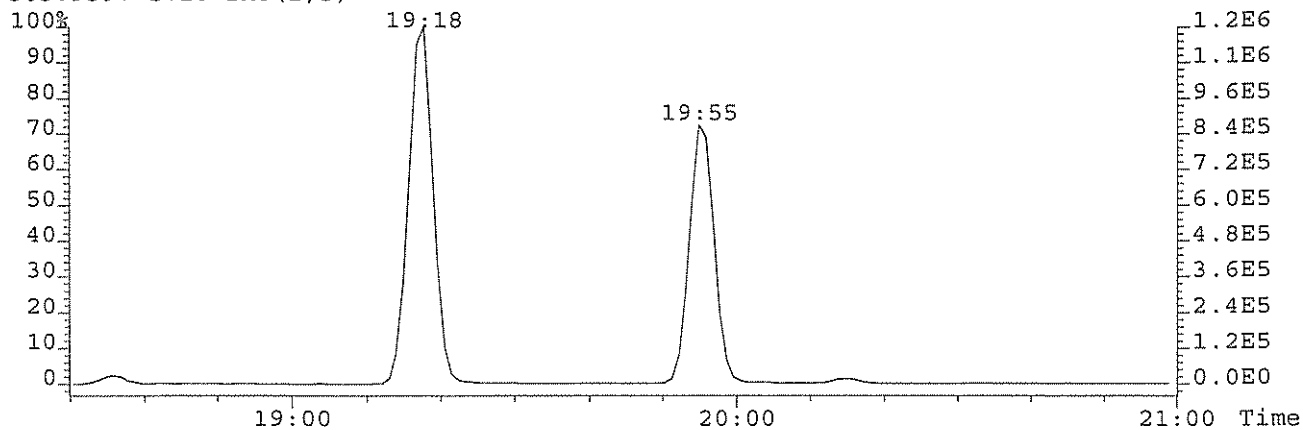
291.9194 S:20 SMO(1,3)



301.9626 S:20 SMO(1,3)



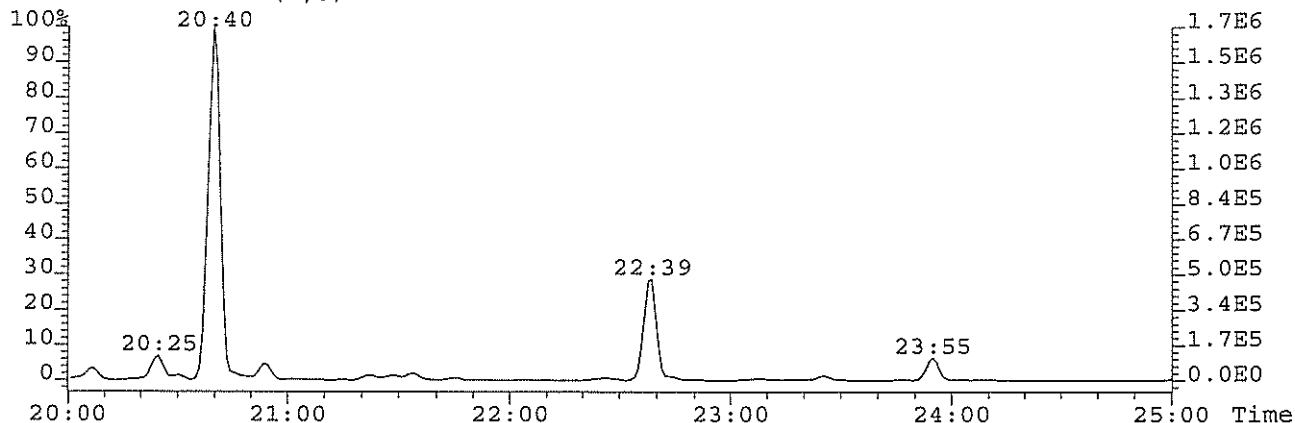
303.9597 S:20 SMO(1,3)



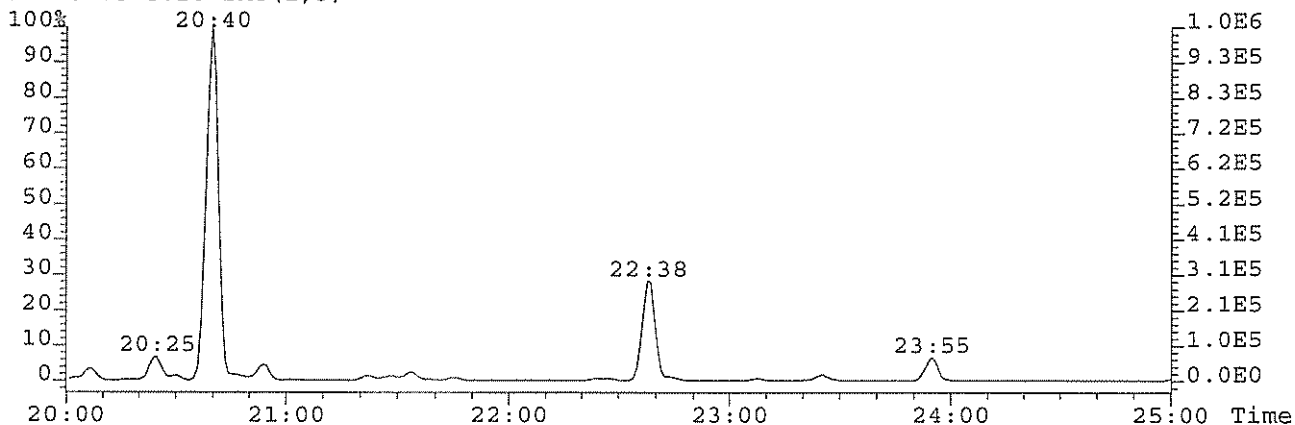
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 10:32:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0958 3 Exp:RH-PD22

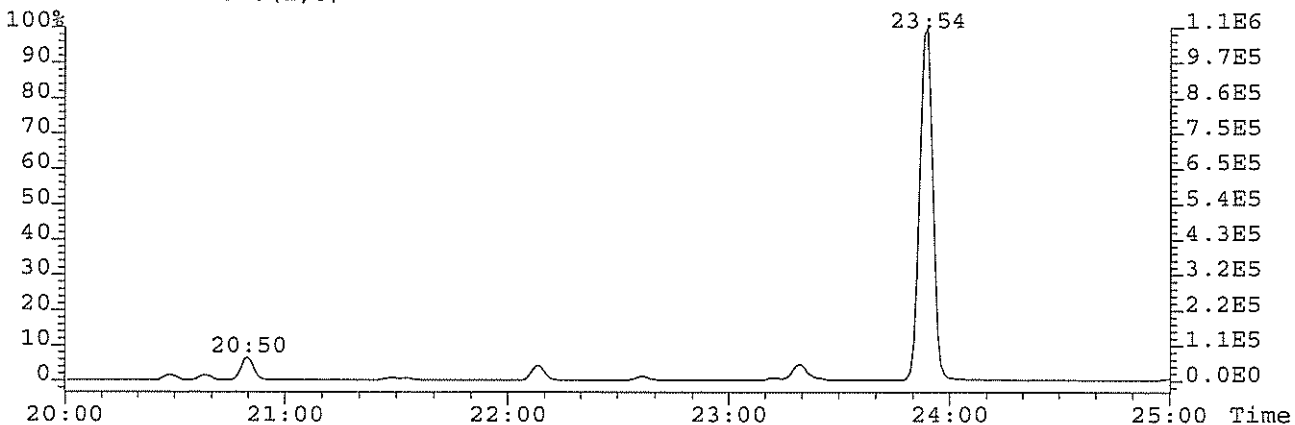
325.8804 S:20 SMO(1,3)



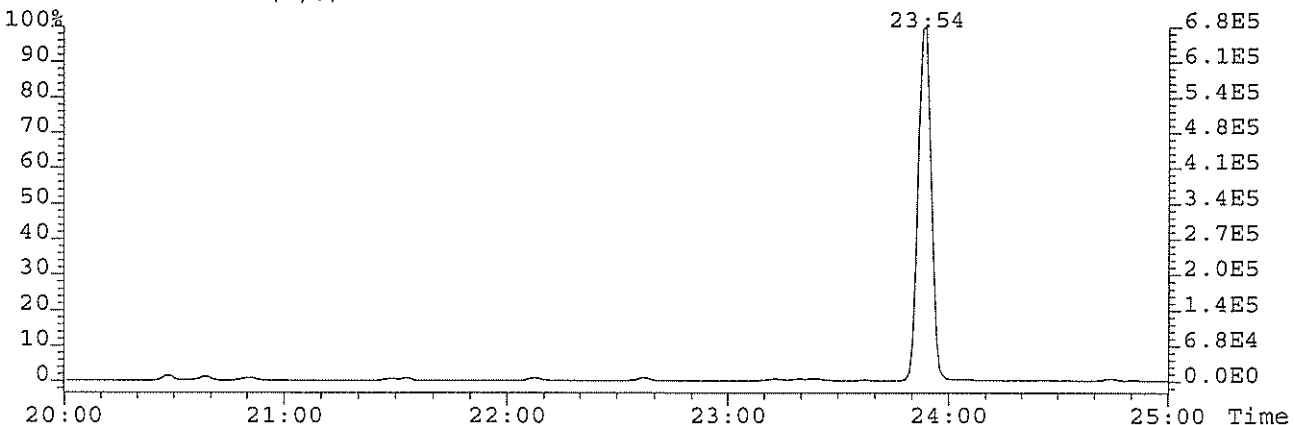
327.8775 S:20 SMO(1,3)



337.9207 S:20 SMO(1,3)

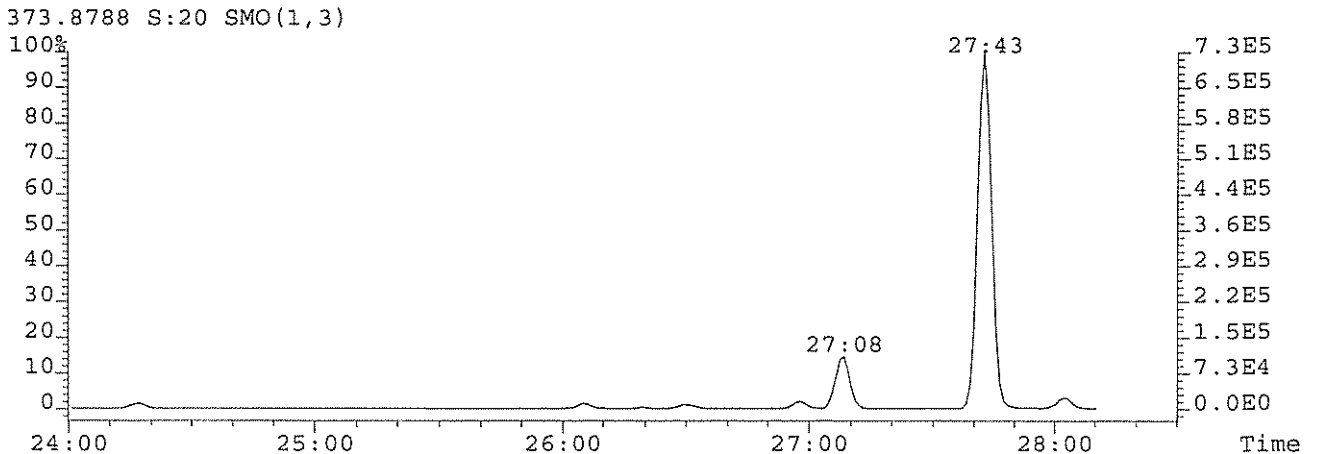
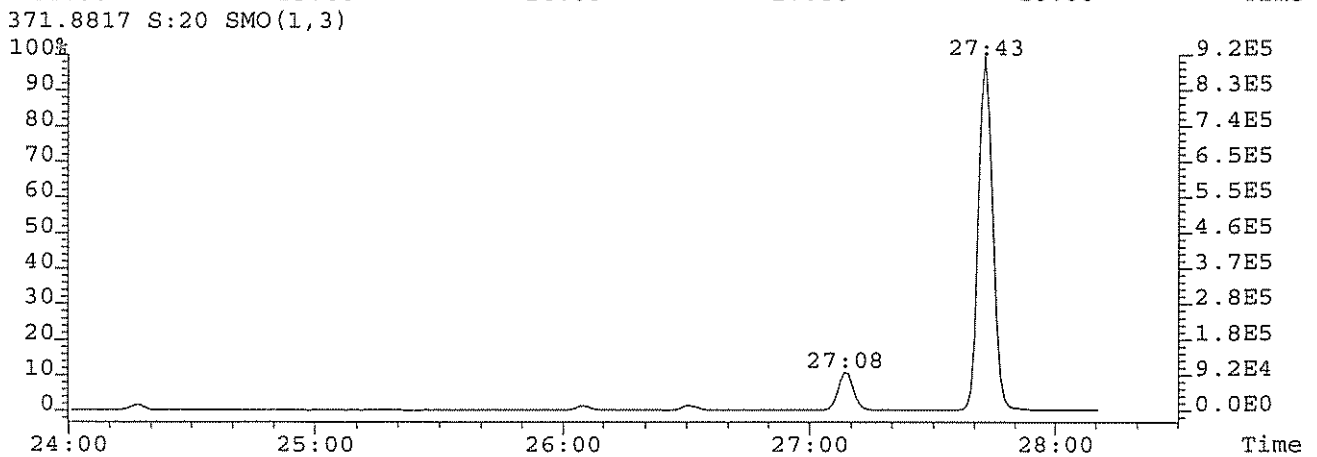
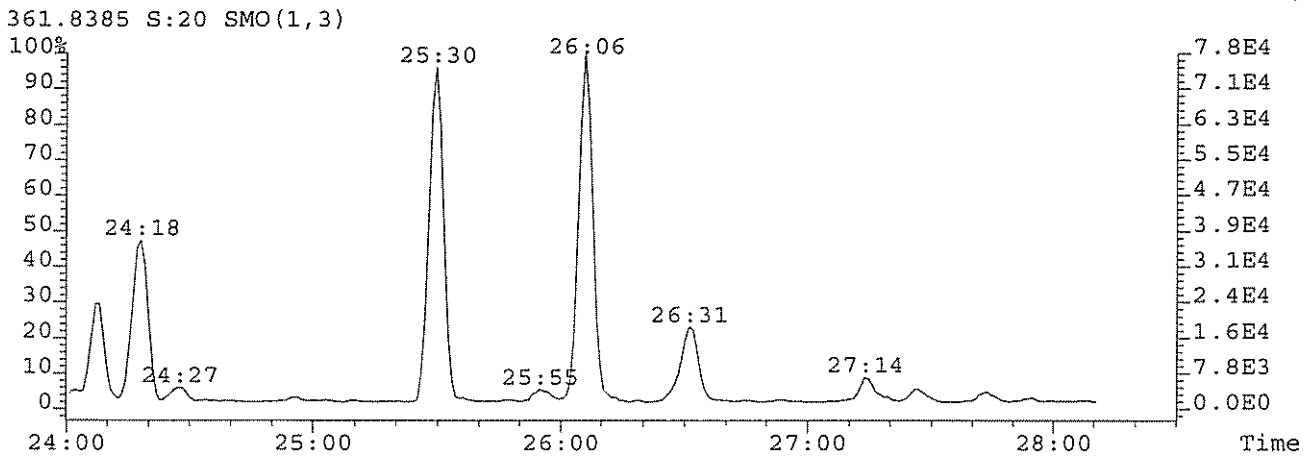
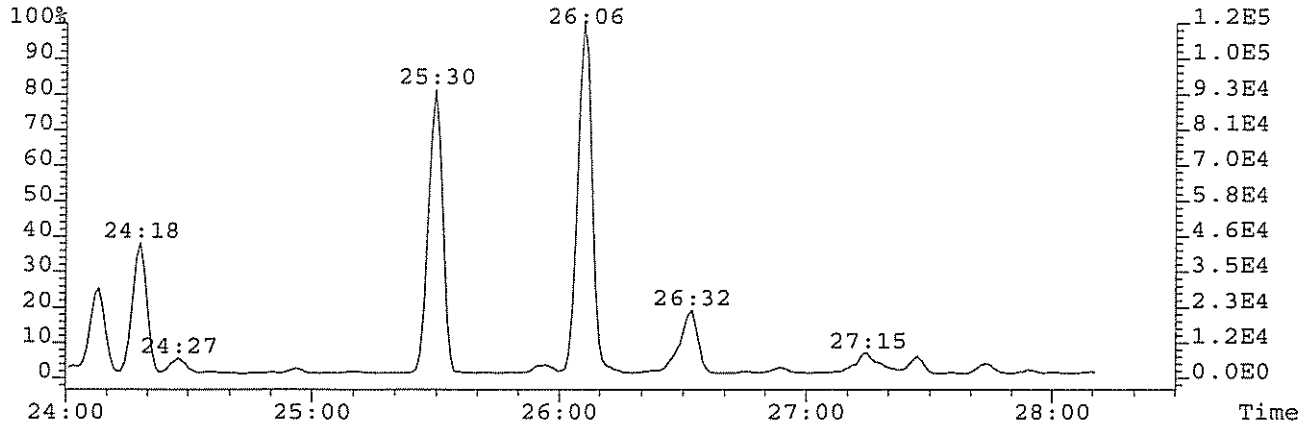


339.9178 S:20 SMO(1,3)



DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

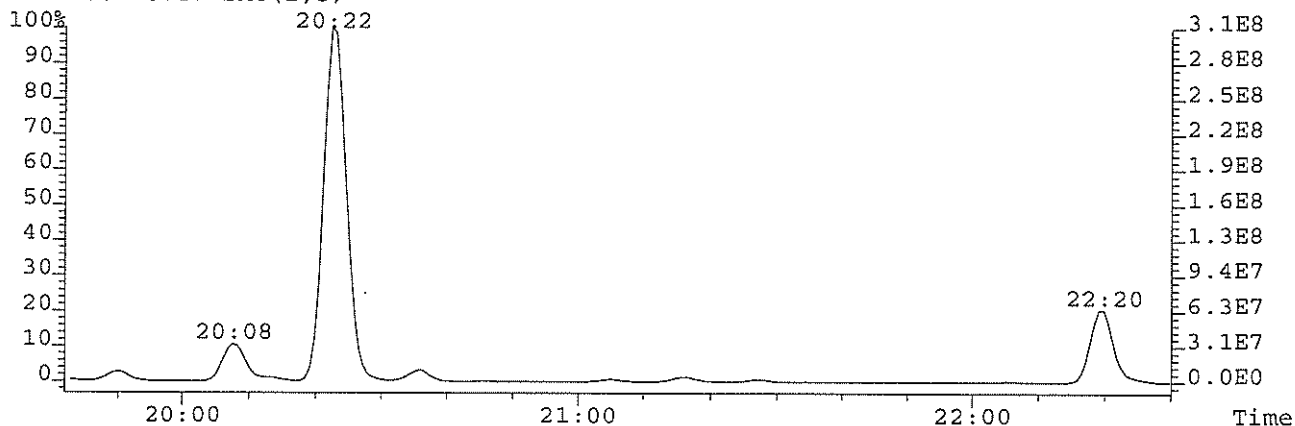
File:130711-2 #1-1430 Acq:12-JUL-2013 10:32:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0958 3 Exp:RH-PD22  
359.8415 S:20 SMO(1,3)



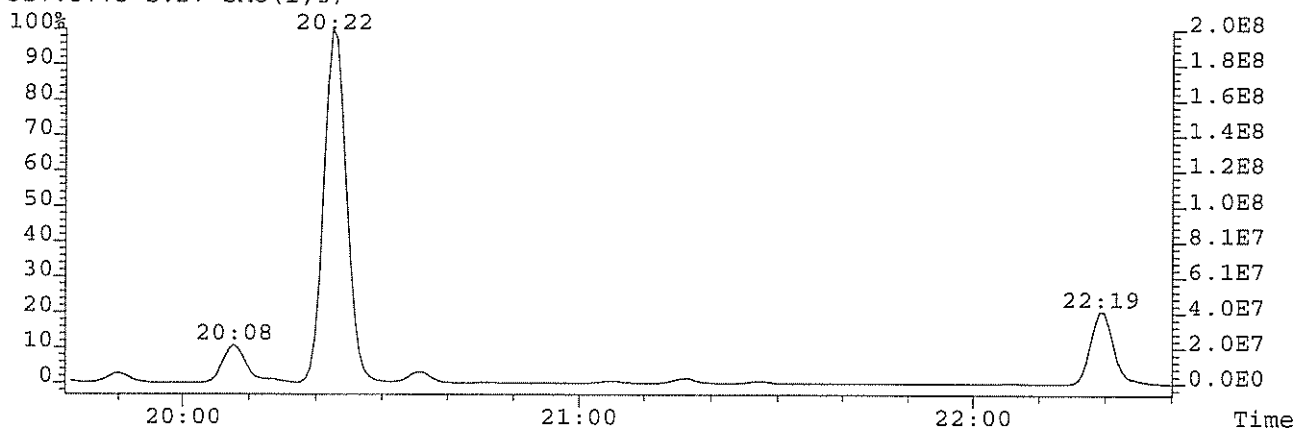
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130713 #1-2899 Acq:14-JUL-2013 06:19:46 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#27 File Text:RH-12ms(mP) Text:XE13 0958 2 Exp:RH-MP11

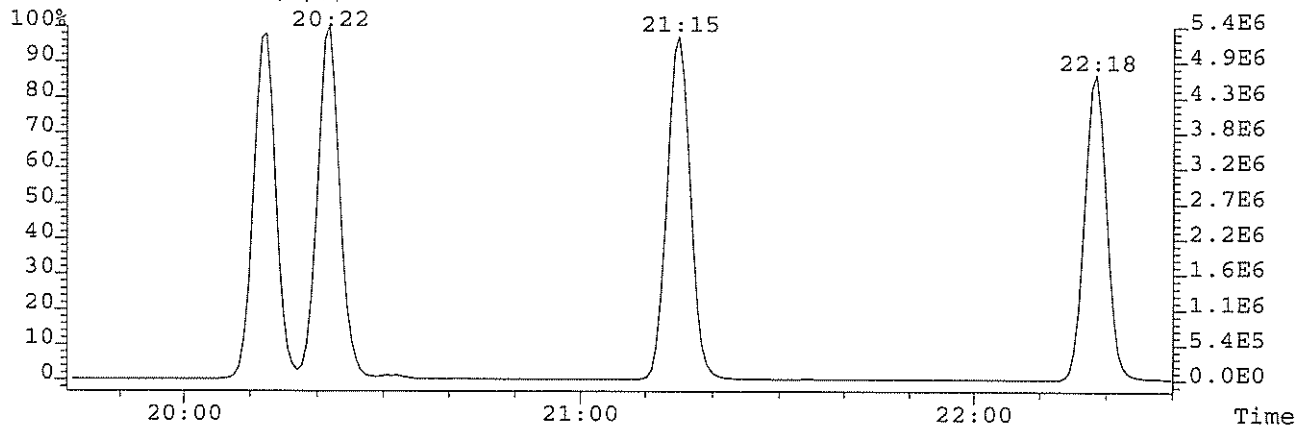
325.8804 S:27 SMO(1,3)



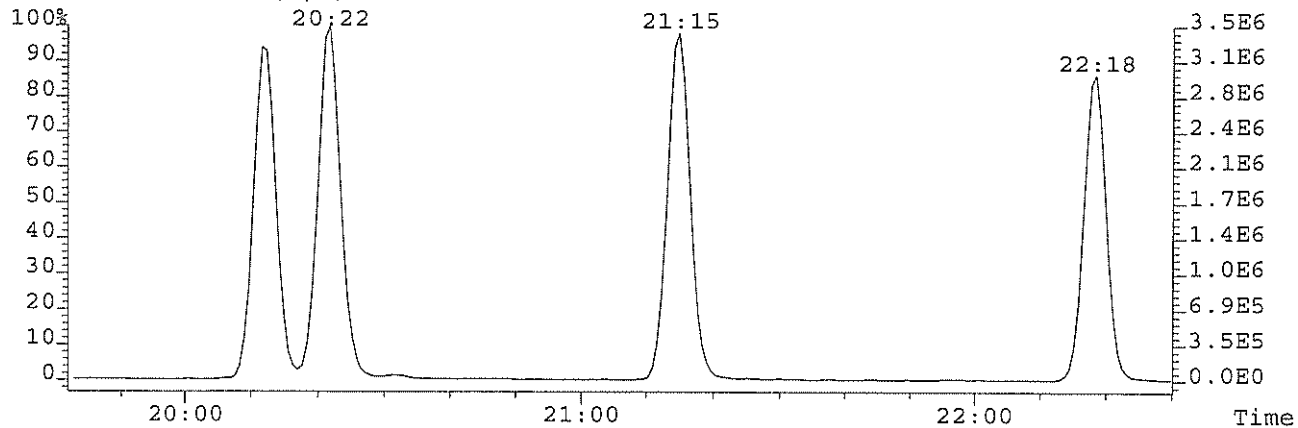
327.8775 S:27 SMO(1,3)



337.9207 S:27 SMO(1,3)



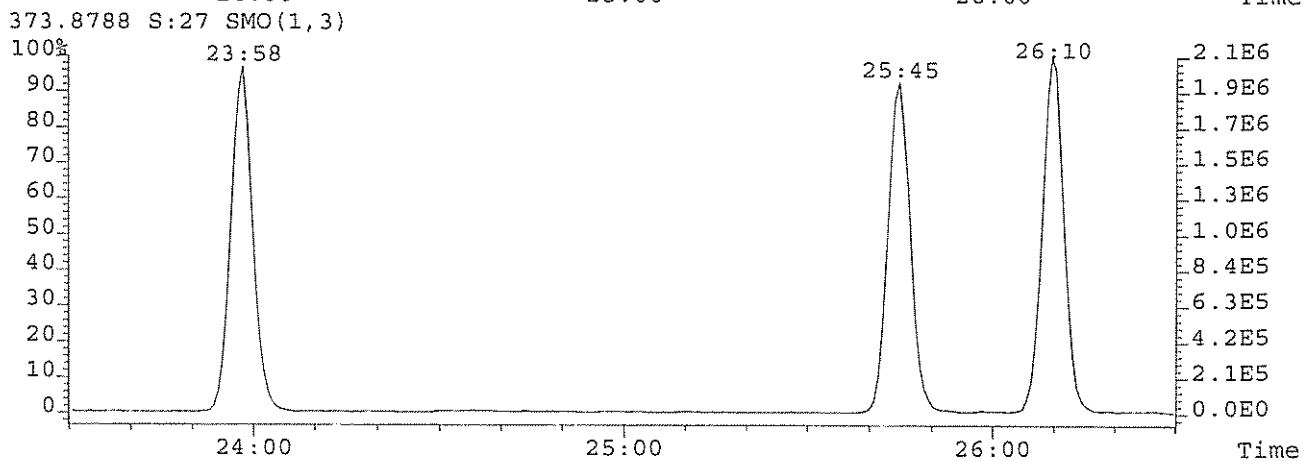
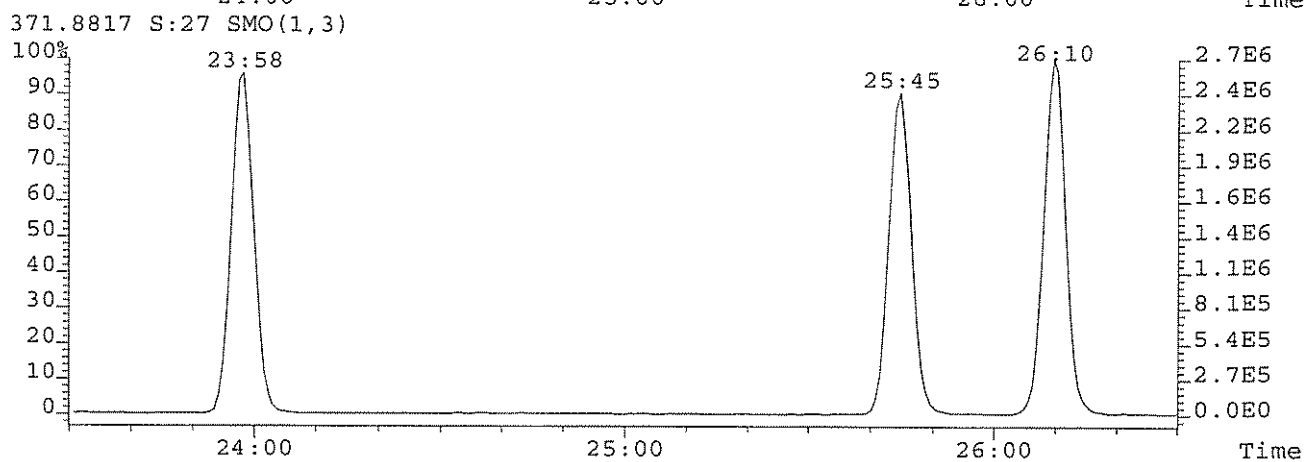
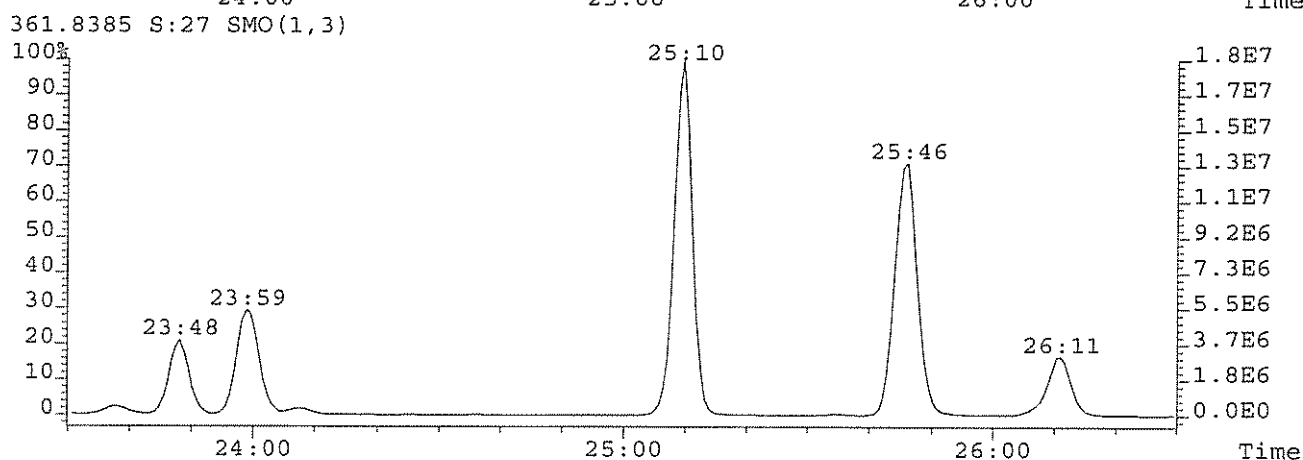
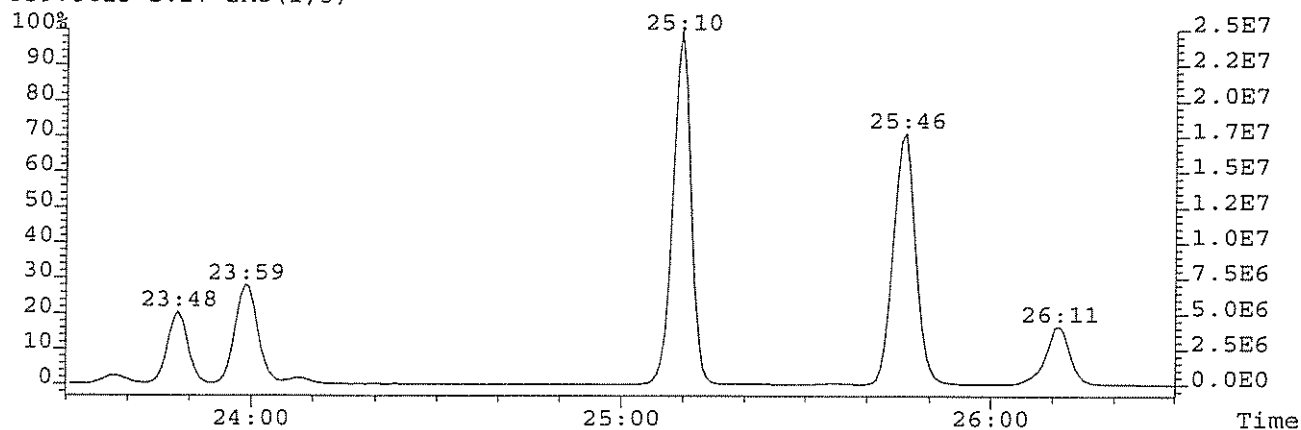
339.9178 S:27 SMO(1,3)



DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

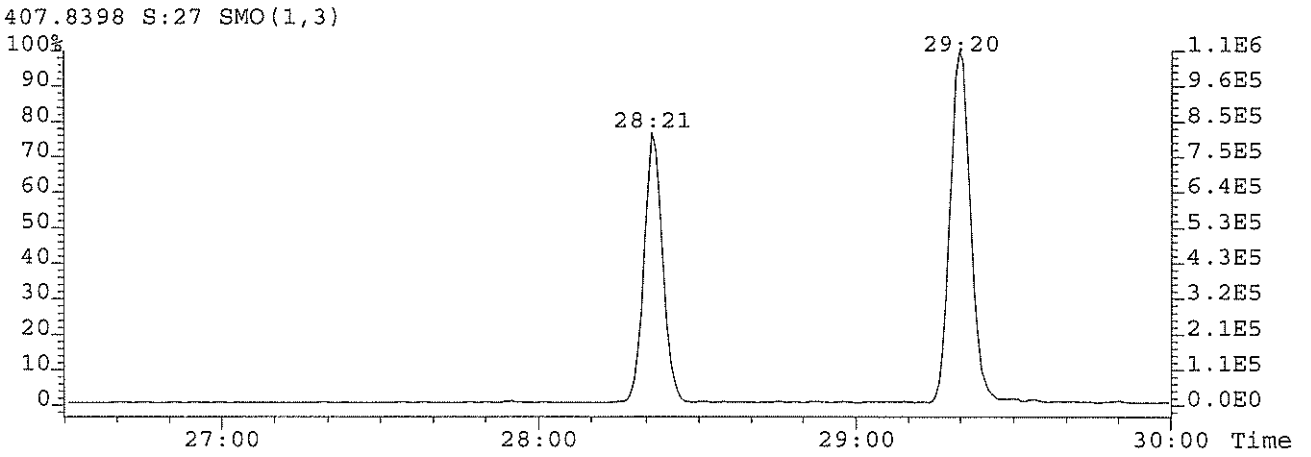
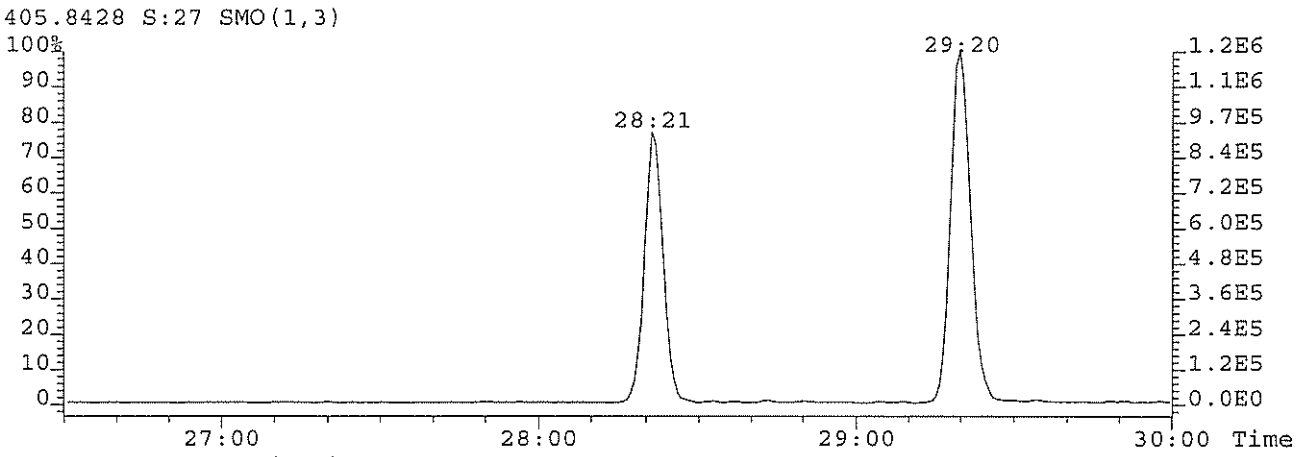
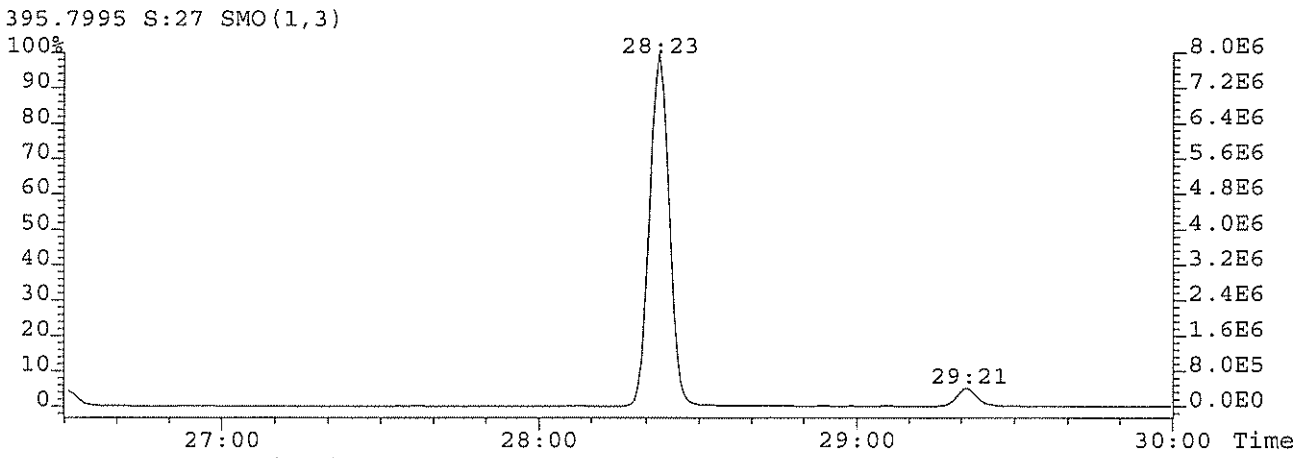
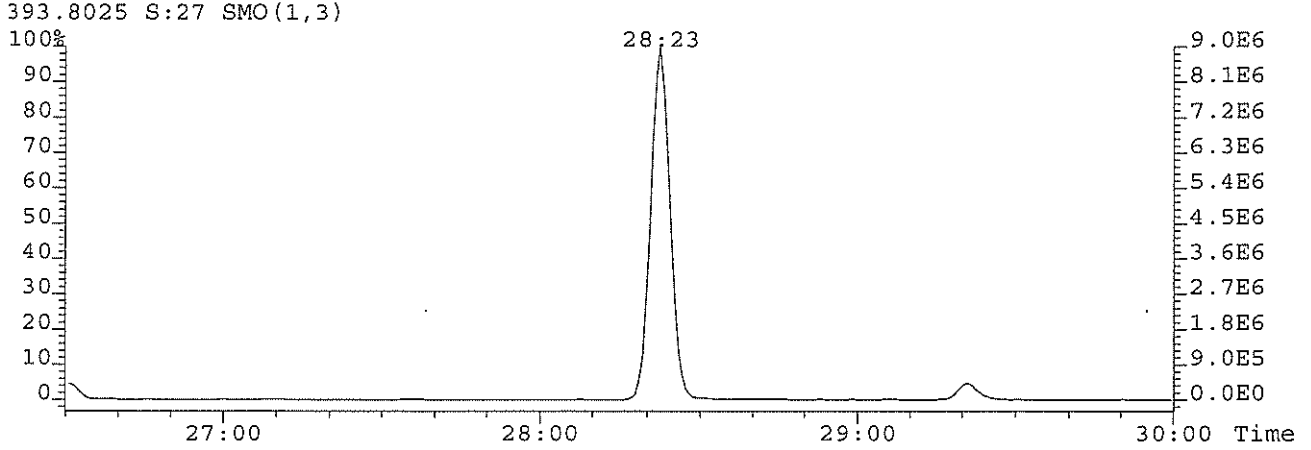


File:130713 #1-2899 Acq:14-JUL-2013 06:19:46 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#27 File Text:RH-12ms(mP) Text:XE13 0958 2 Exp:RH-MP11  
359.8415 S:27 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130713 #1-2899 Acq:14-JUL-2013 06:19:46 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#27 File Text:RH-12ms(mP) Text:XE13 0958 2 Exp:RH-MP11

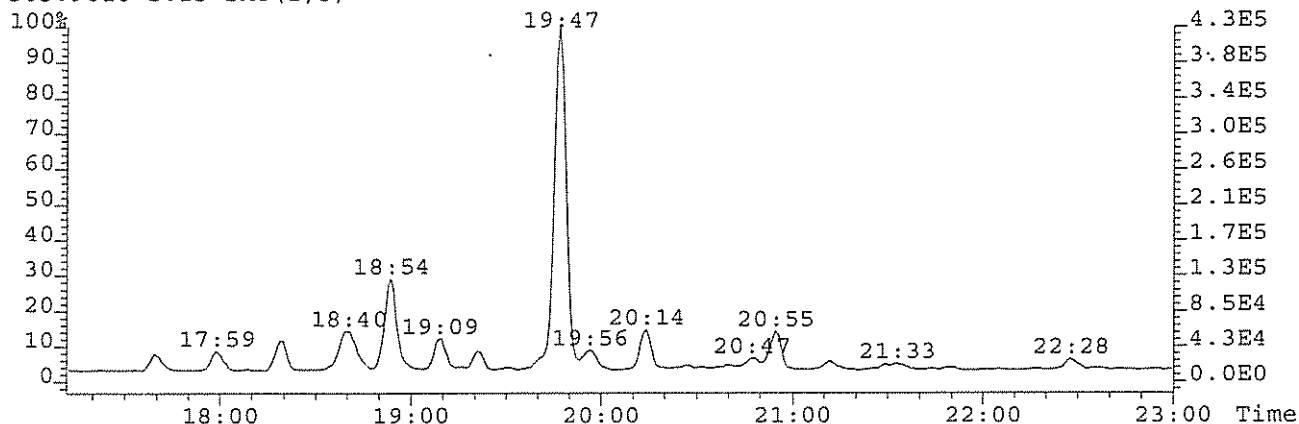


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

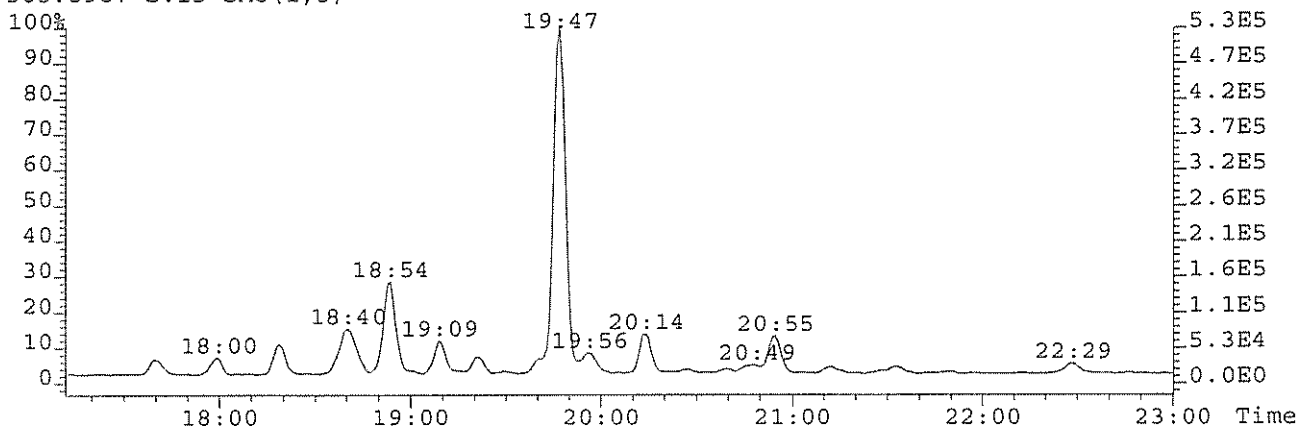
試料管理番号	XE 130959
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.13

File:130716-2 #1-1578 Acq:17-JUL-2013 04:54:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:BPX-DXN(4-6DXN) Text:XE13 0959 Exp:BPX04

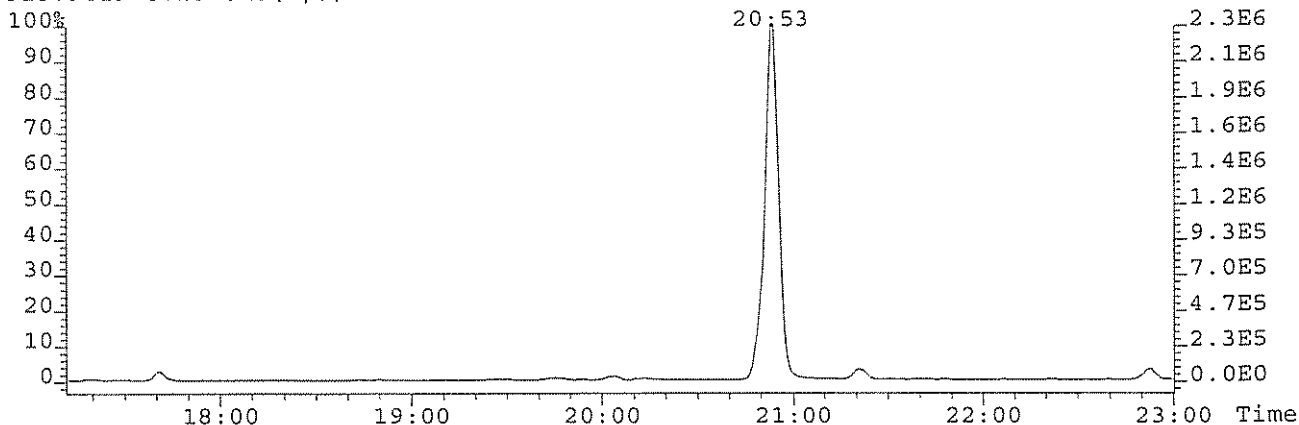
303.9016 S:15 SMO(1,3)



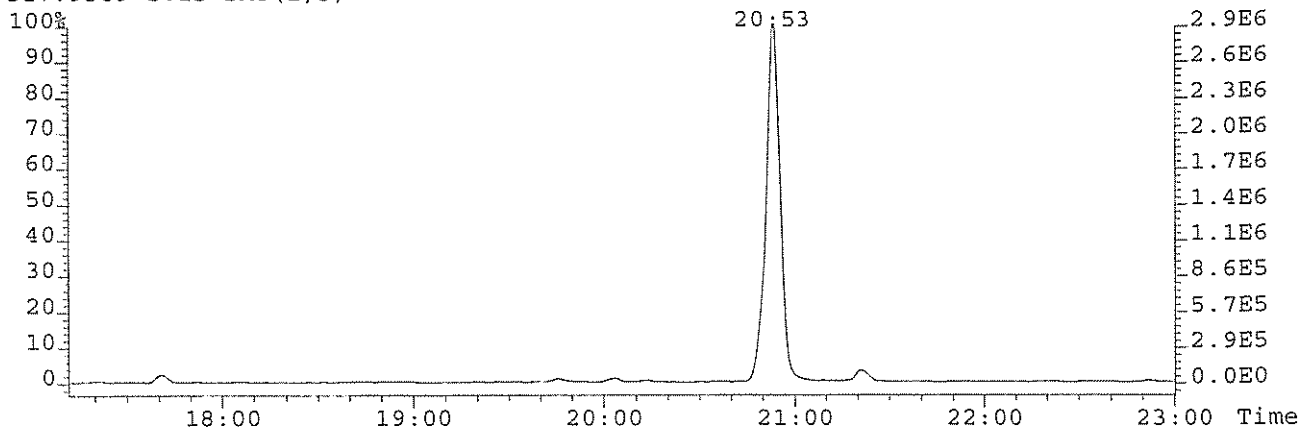
305.8987 S:15 SMO(1,3)



315.9419 S:15 SMO(1,3)



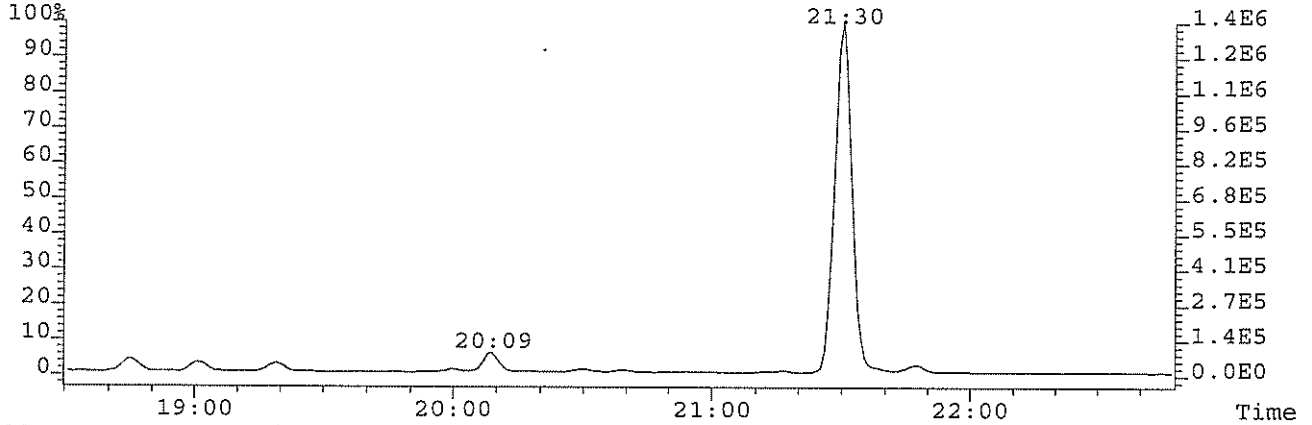
317.9389 S:15 SMO(1,3)



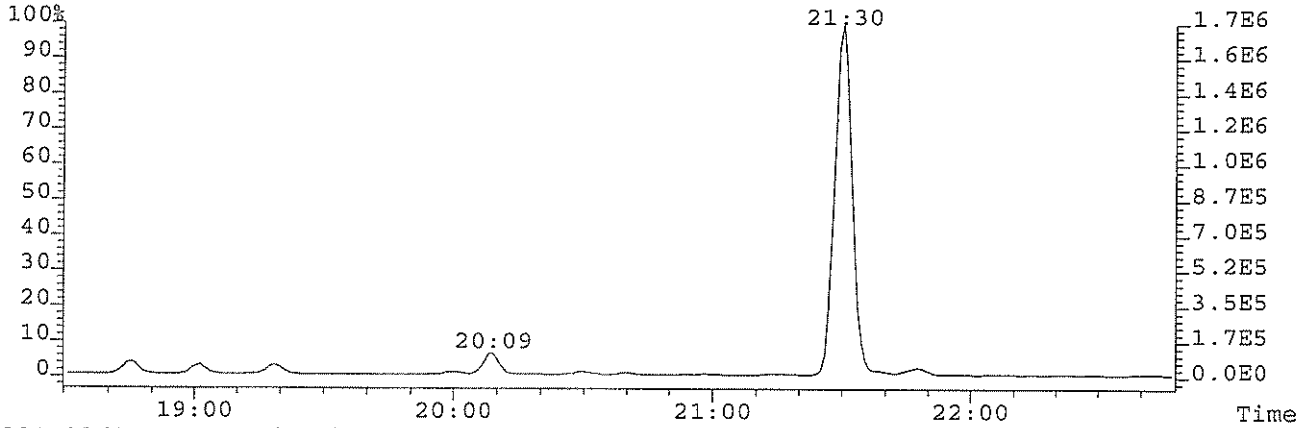
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130716-2 #1-1578 Acq:17-JUL-2013 04:54:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:BPX-DXN(4-6DXN) Text:XE13 0959 Exp:BPX04

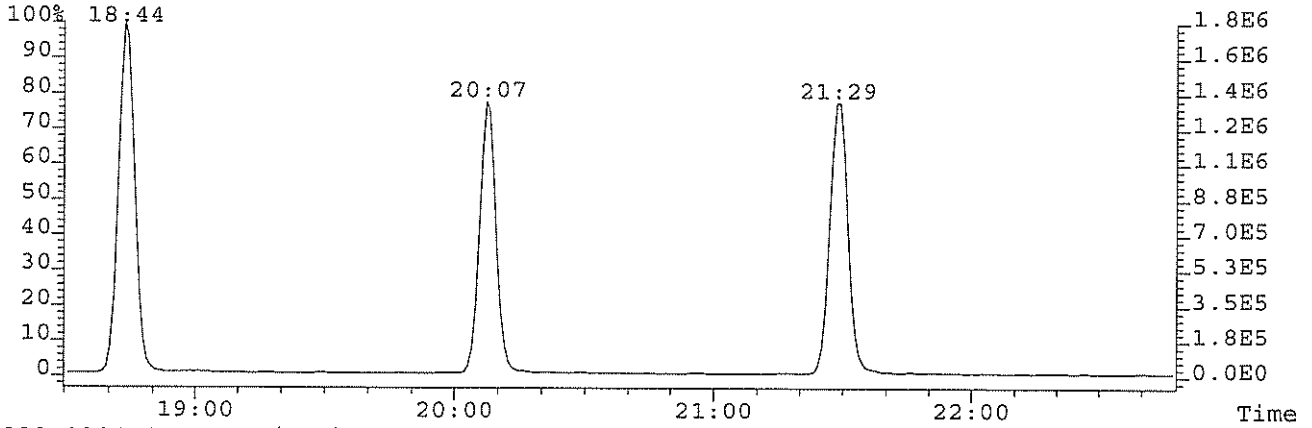
319.8965 S:15 SMO(1,3)



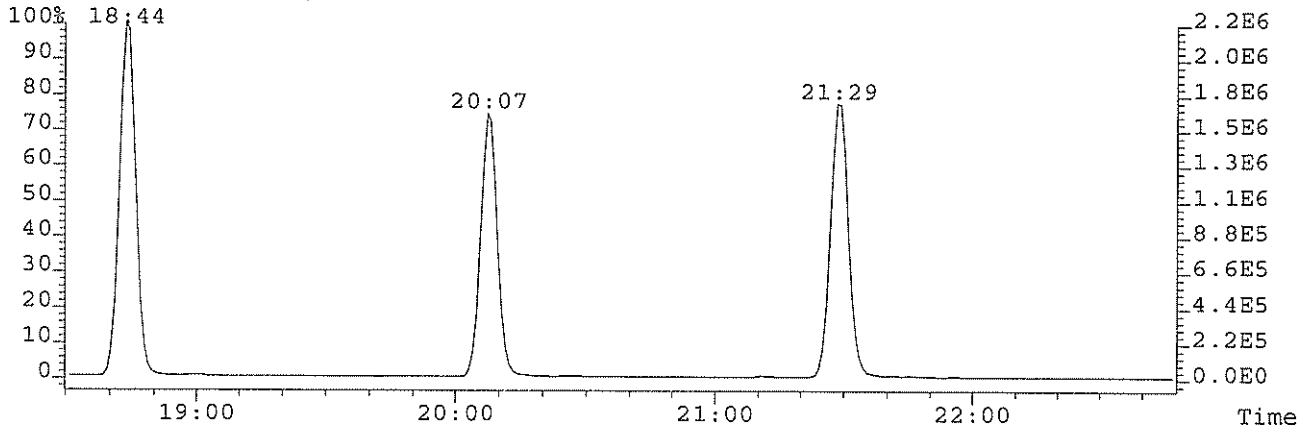
321.8936 S:15 SMO(1,3)



331.9368 S:15 SMO(1,3)



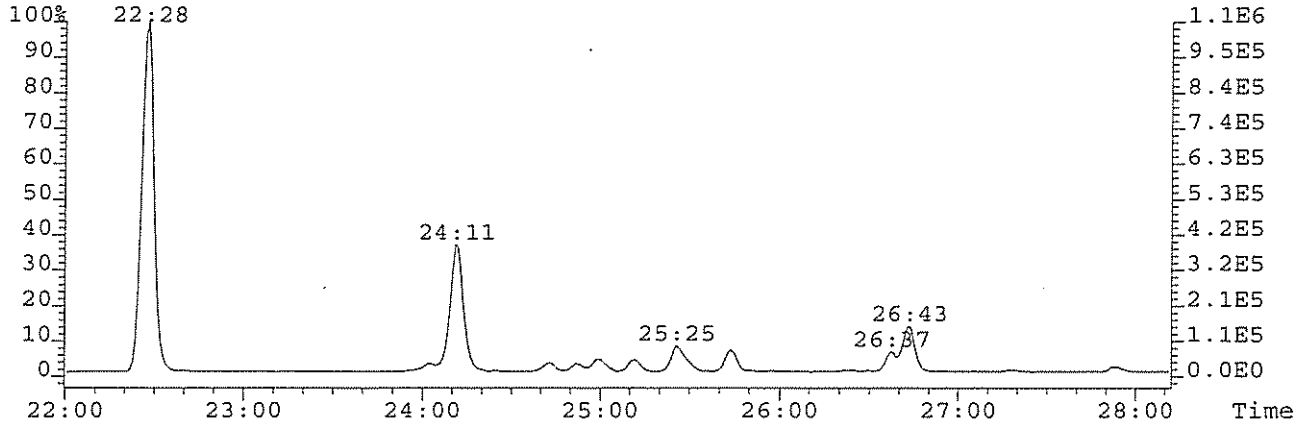
333.9339 S:15 SMO(1,3)



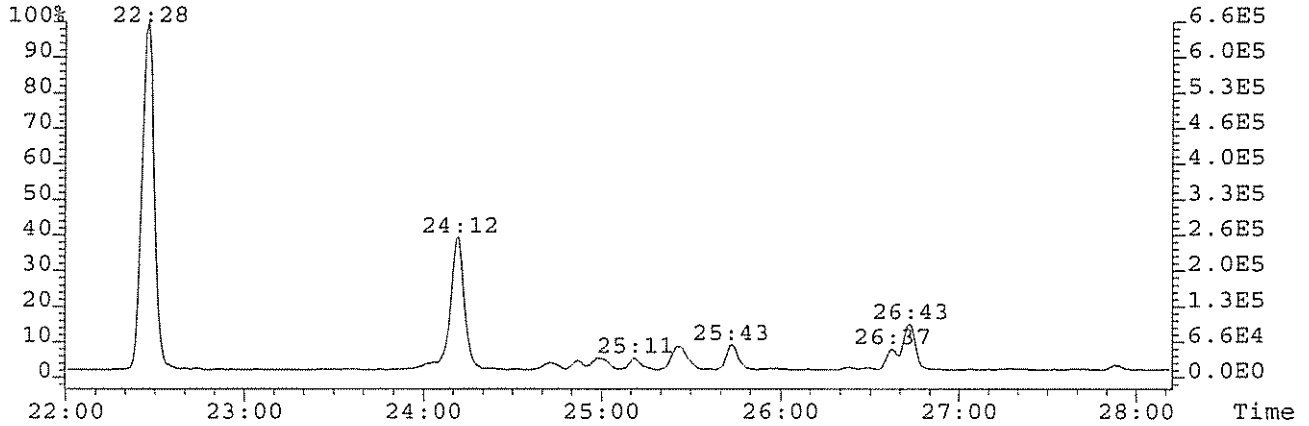
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130716-2 #1-1578 Acq:17-JUL-2013 04:54:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:BPX-DXN(4-6DXN) Text:XE13 0959 Exp:BPX04

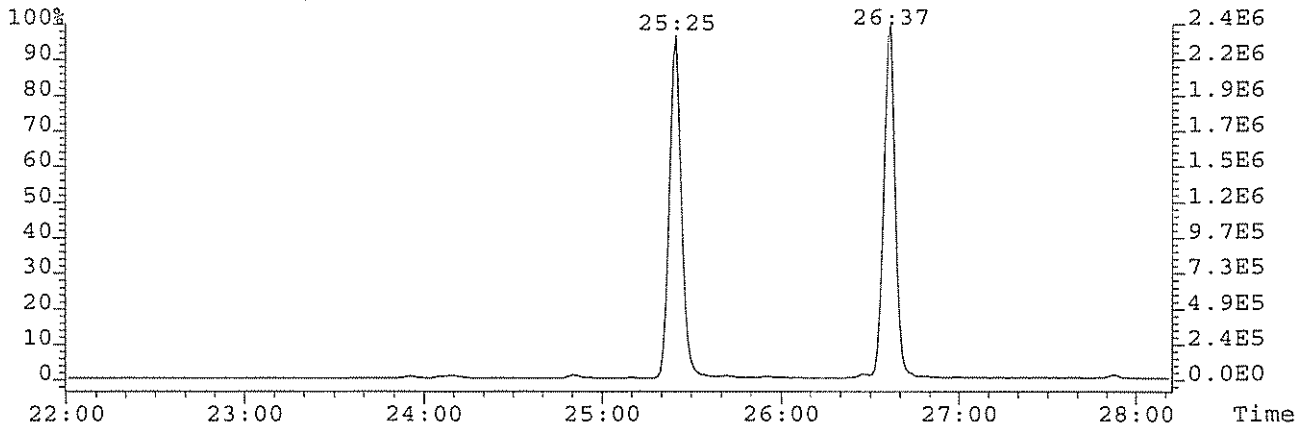
339.8597 S:15 SMO(1,3)



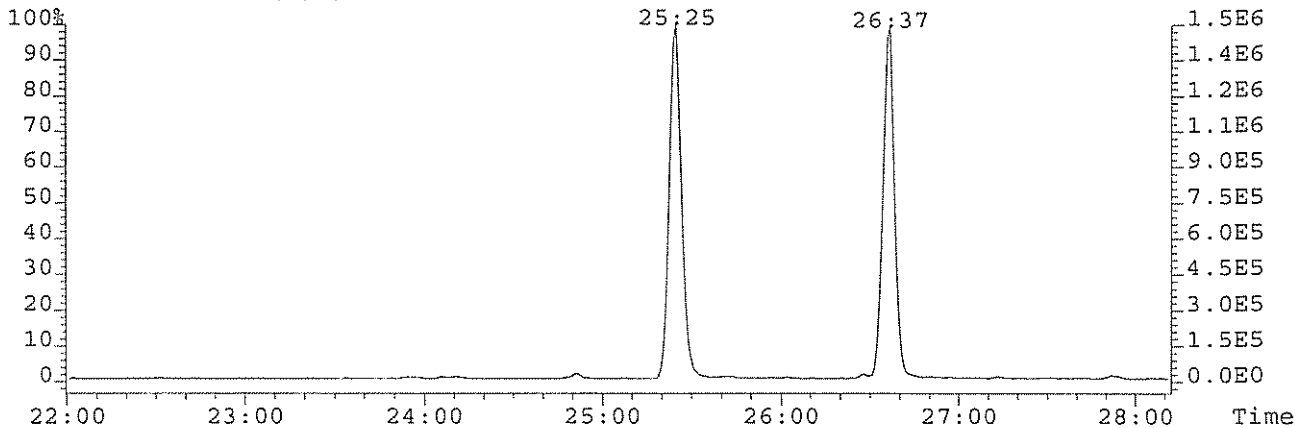
341.8568 S:15 SMO(1,3)



351.9000 S:15 SMO(1,3)



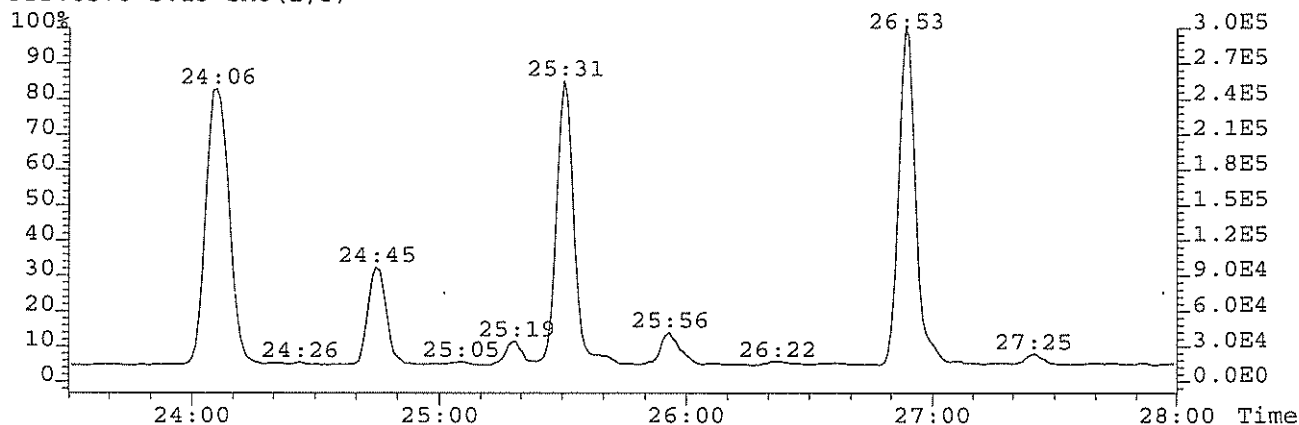
353.8970 S:15 SMO(1,3)



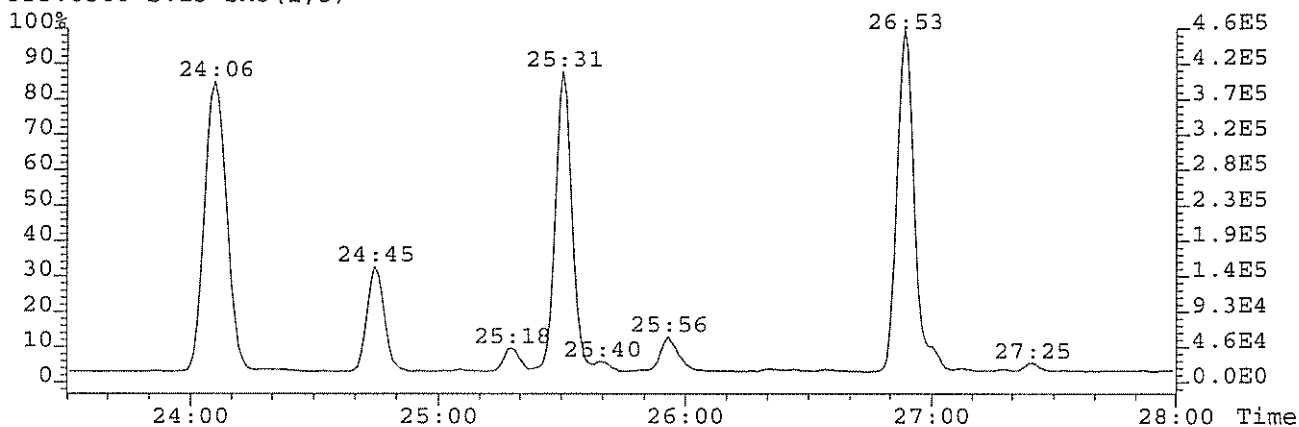
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130716-2 #1-1578 Acq:17-JUL-2013 04:54:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:BPX-DXN(4-6DXN) Text:XE13 0959 Exp:BPX04

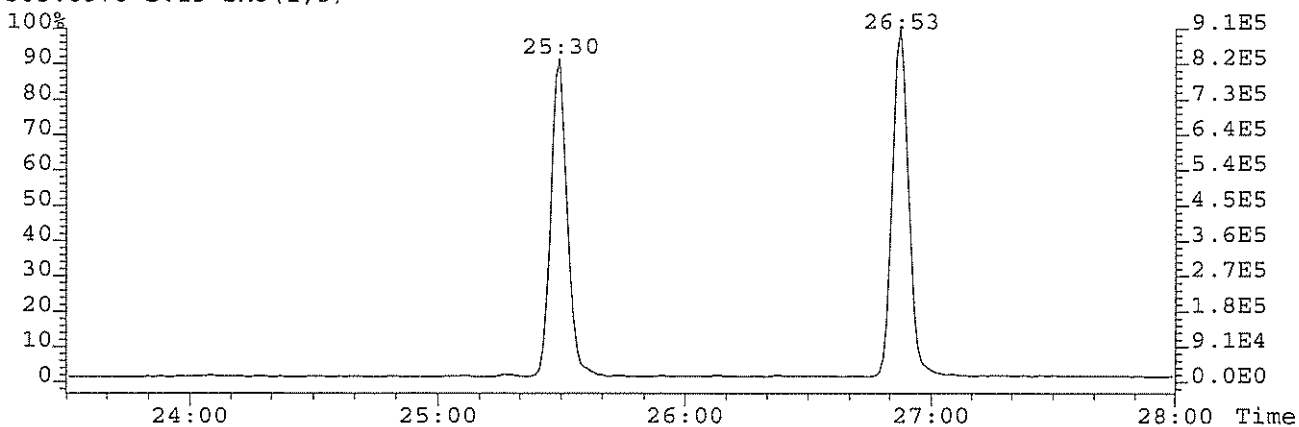
353.8576 S:15 SMO(1,3)



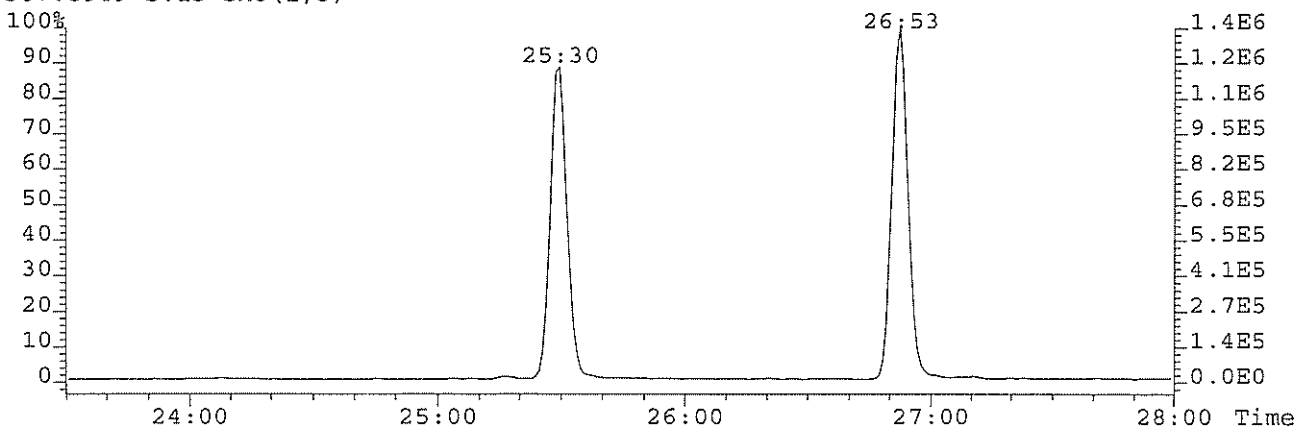
355.8546 S:15 SMO(1,3)



365.8978 S:15 SMO(1,3)

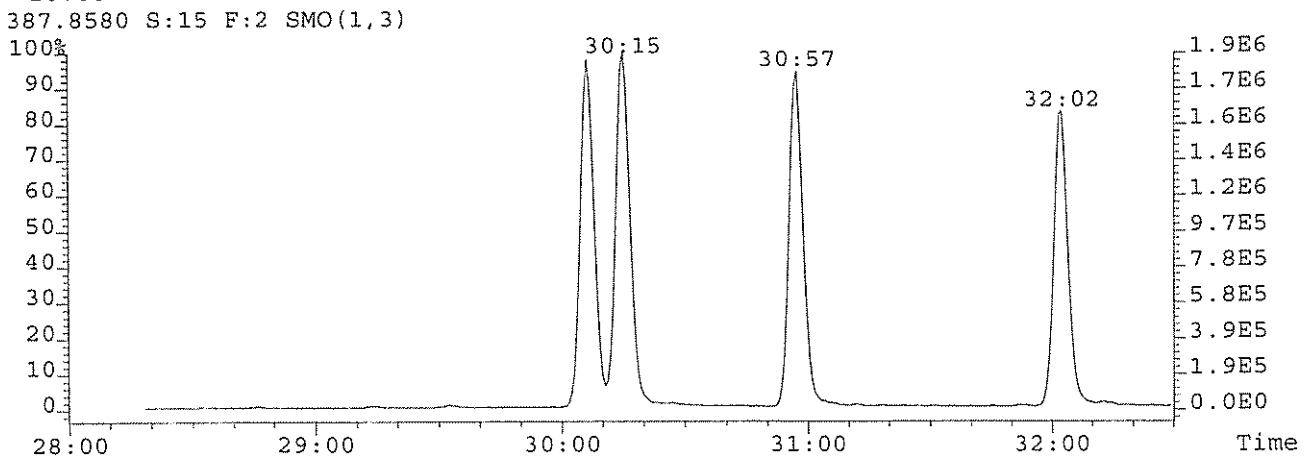
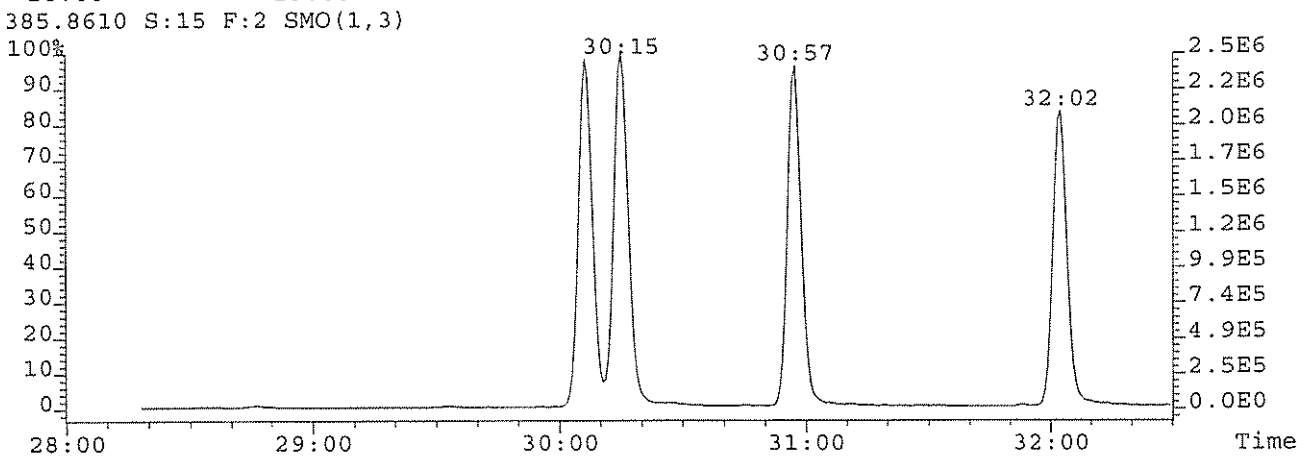
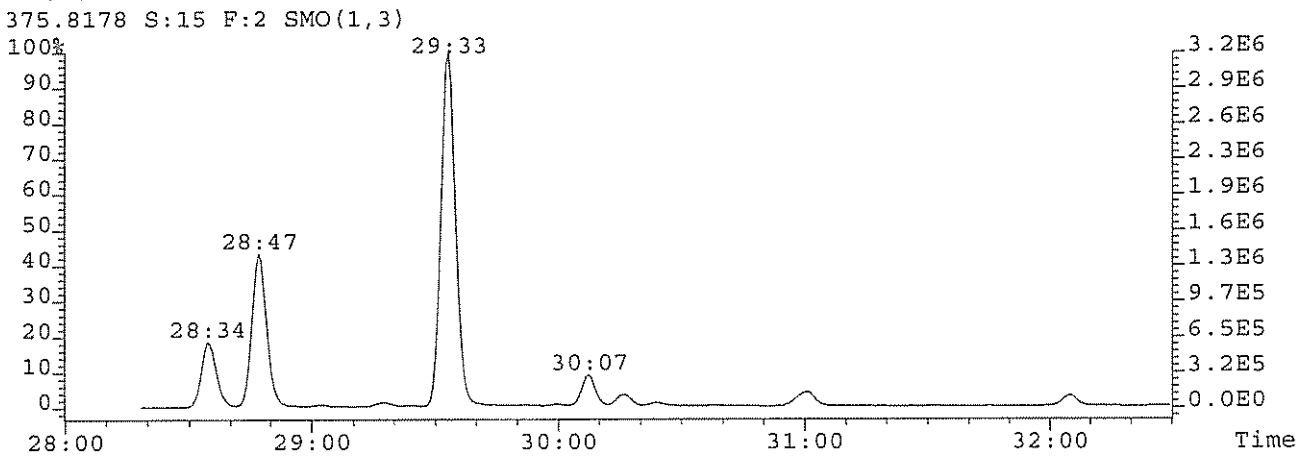
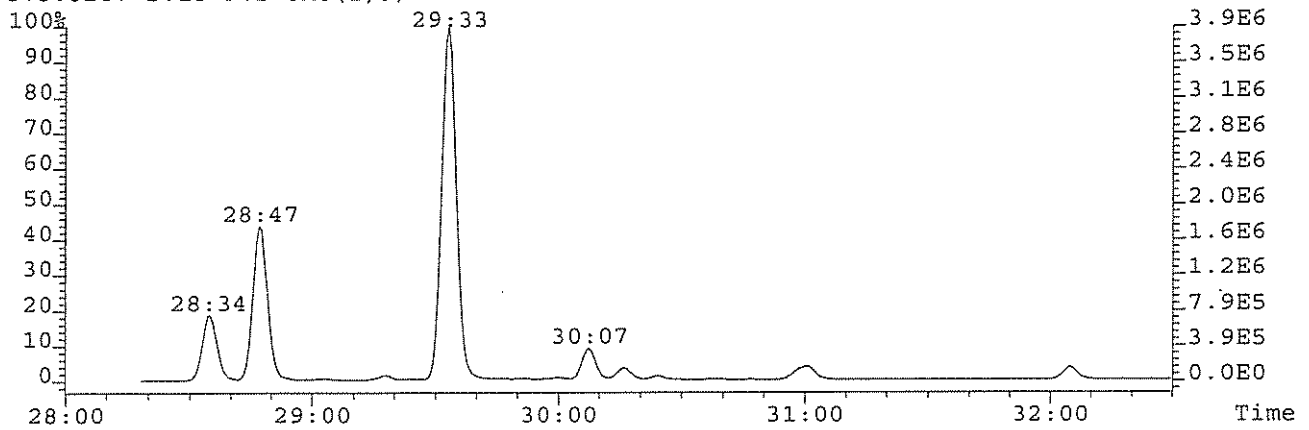


367.8949 S:15 SMO(1,3)



PCDDsクロマトグラム (4)  
(PeCDDs)

File:130716-2 #1-1117 Acq:17-JUL-2013 04:54:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:BPX-DXN(4-6DXN) Text:XE13 0959 Exp:BPX04  
373.8207 S:15 F:2 SMO(1,3)

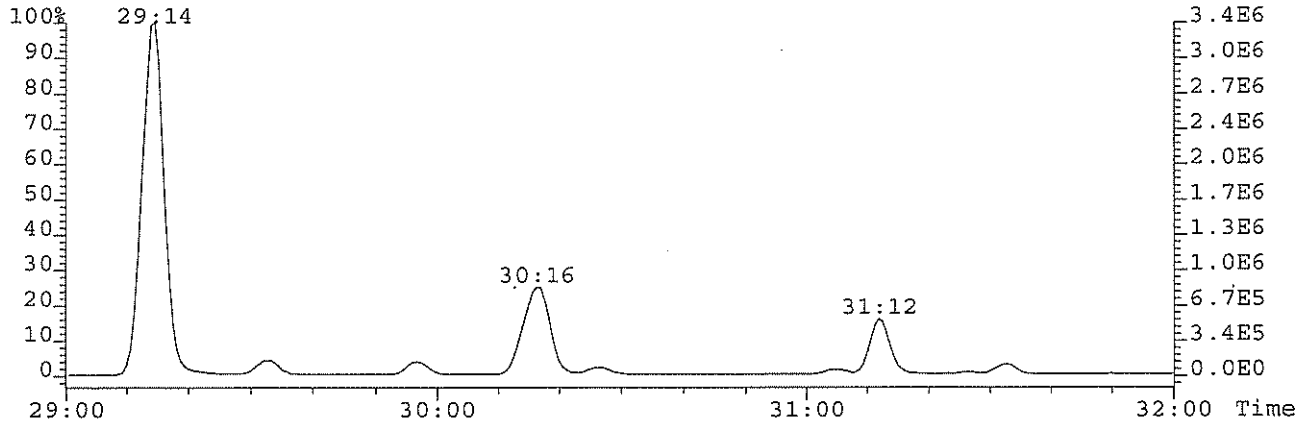


PCDFsクロマトグラム (5)  
(HxCDFs)

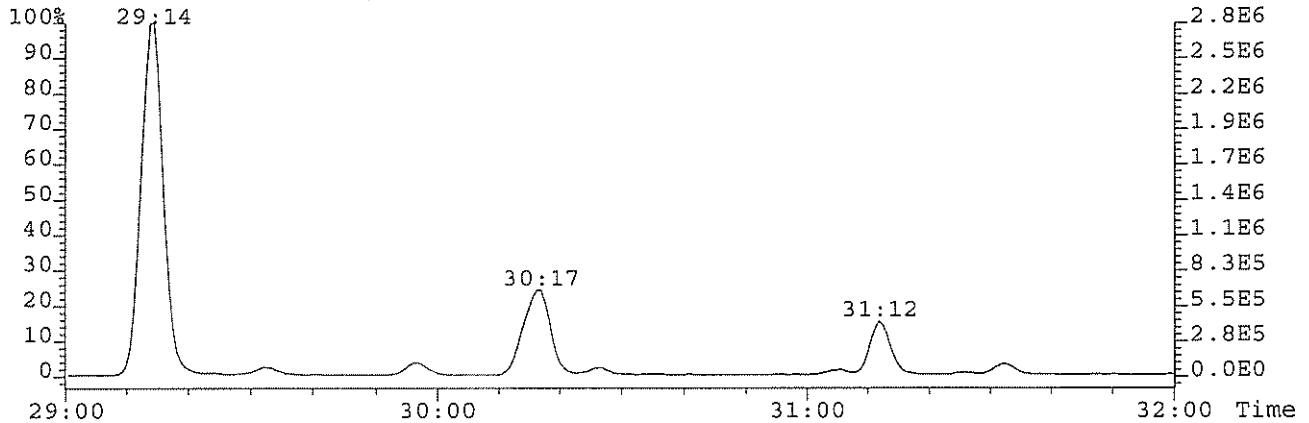


File:130716-2 #1-1117 Acq:17-JUL-2013 04:54:34 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:BPX-DXN(4-6DXN) Text:XE13 0959 Exp:BPX04

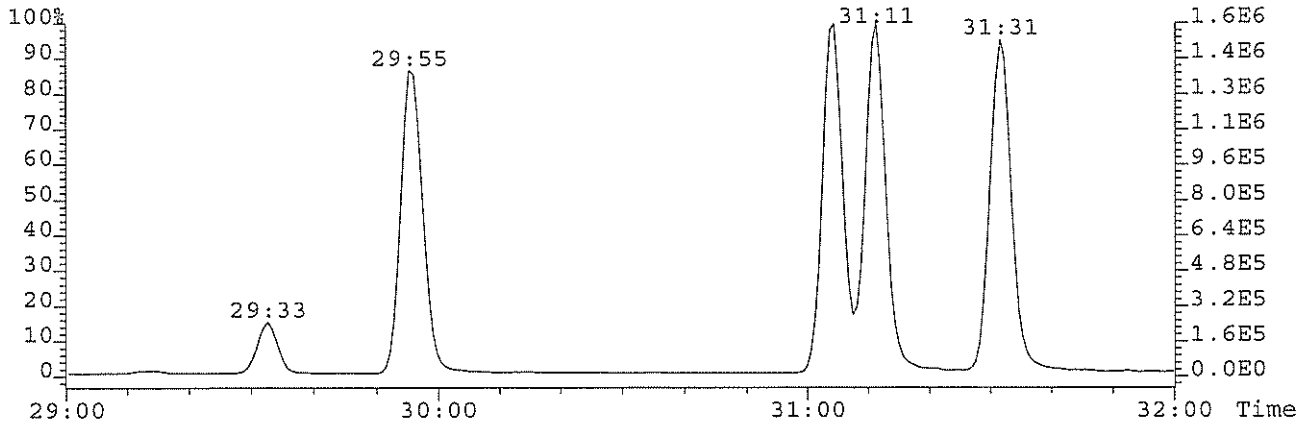
389.8156 S:15 F:2 SMO(1,3)



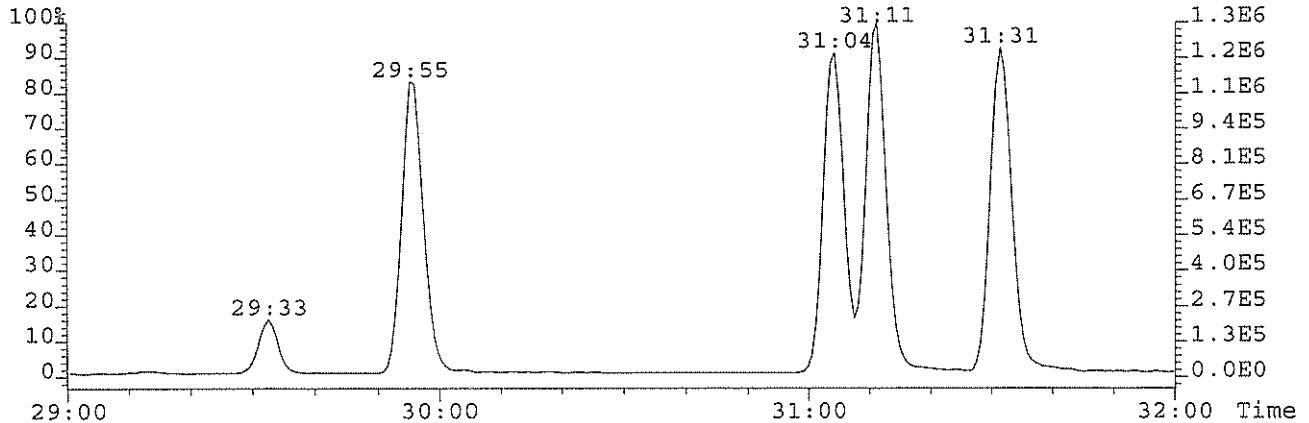
391.8127 S:15 F:2 SMO(1,3)



401.8559 S:15 F:2 SMO(1,3)

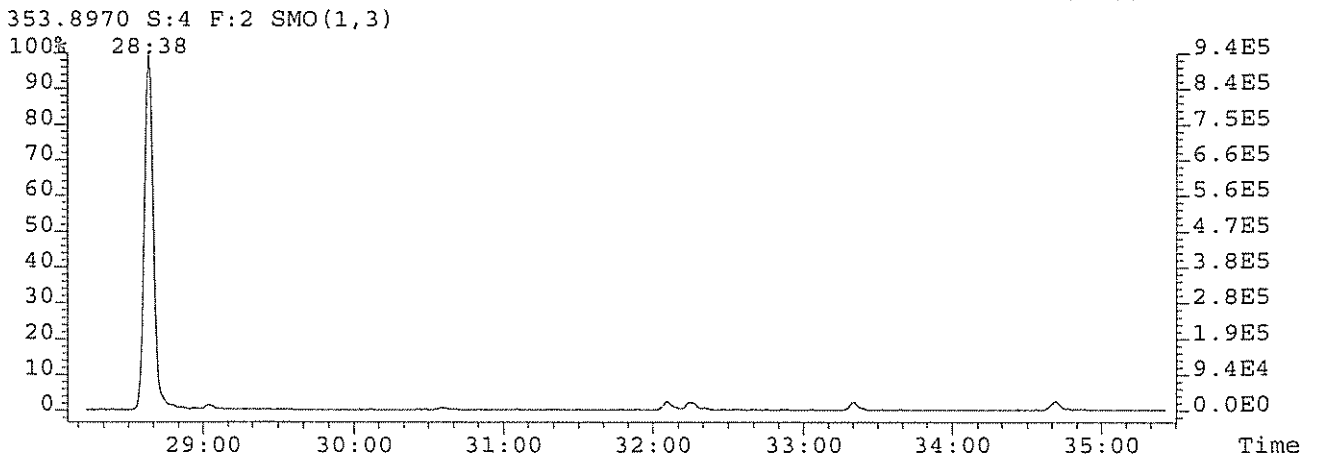
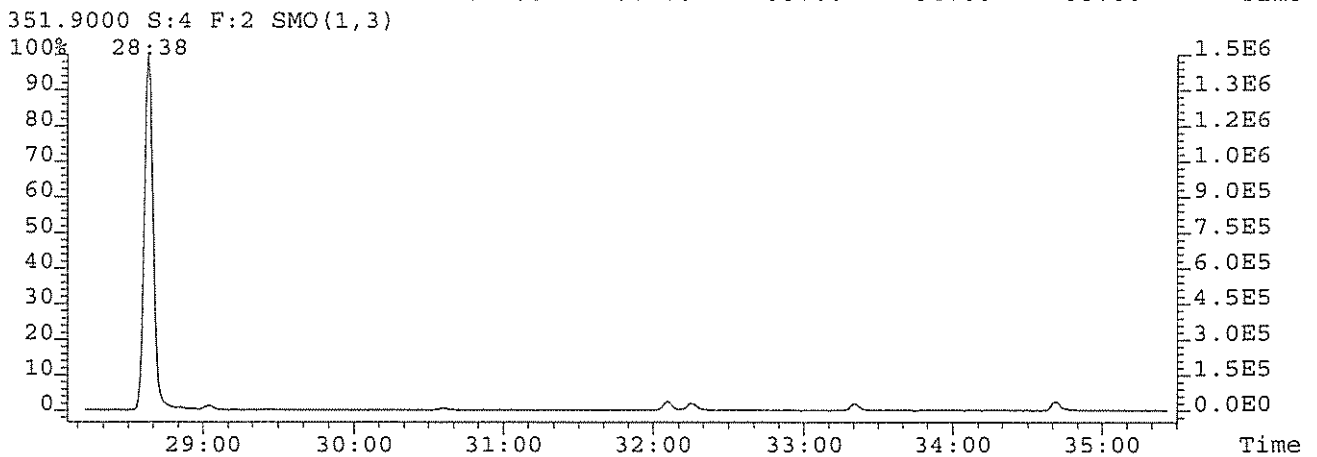
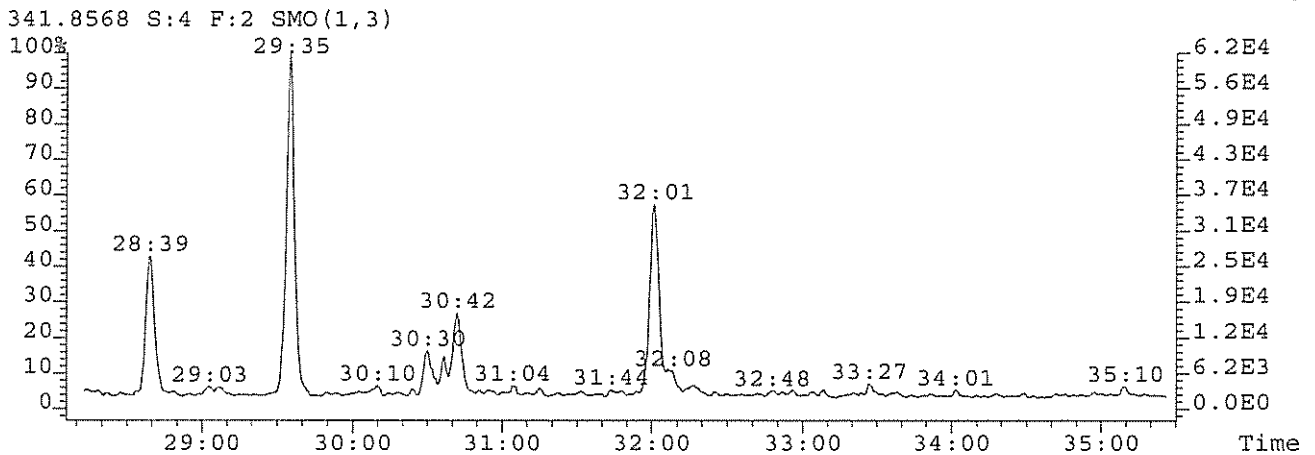
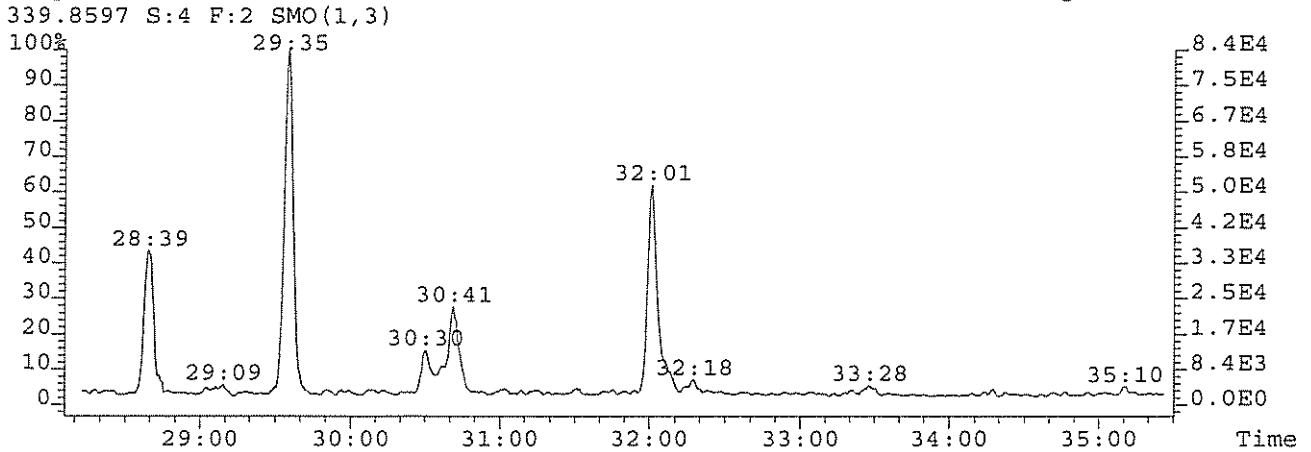


403.8530 S:15 F:2 SMO(1,3)



PCDDsクロマトグラム (6)  
(HxCDDs)

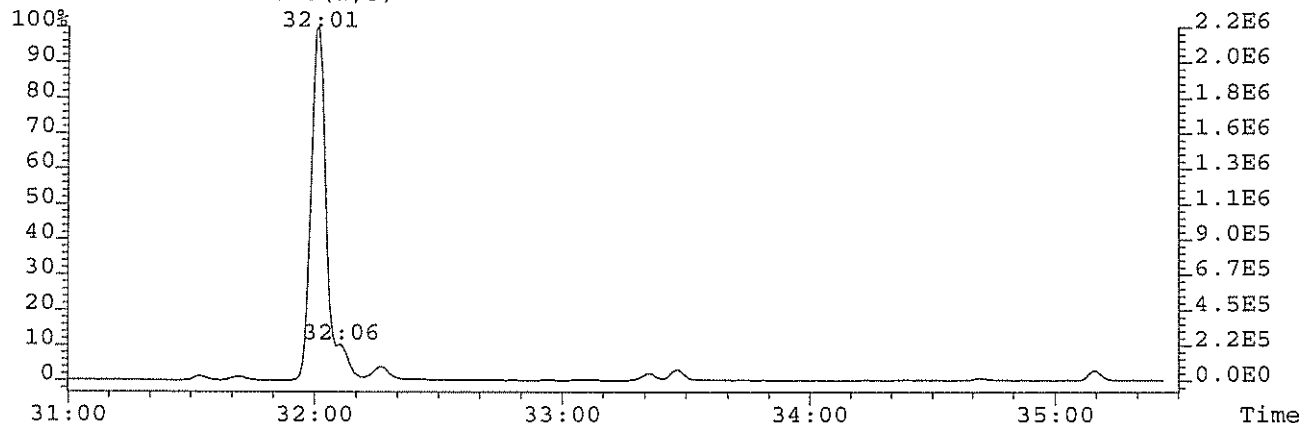
File:130717 #1-649 Acq:17-JUL-2013 11:52:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:RH-12ms(5-8,nP) Text:XE13 0959 3 Exp:RH-PD22



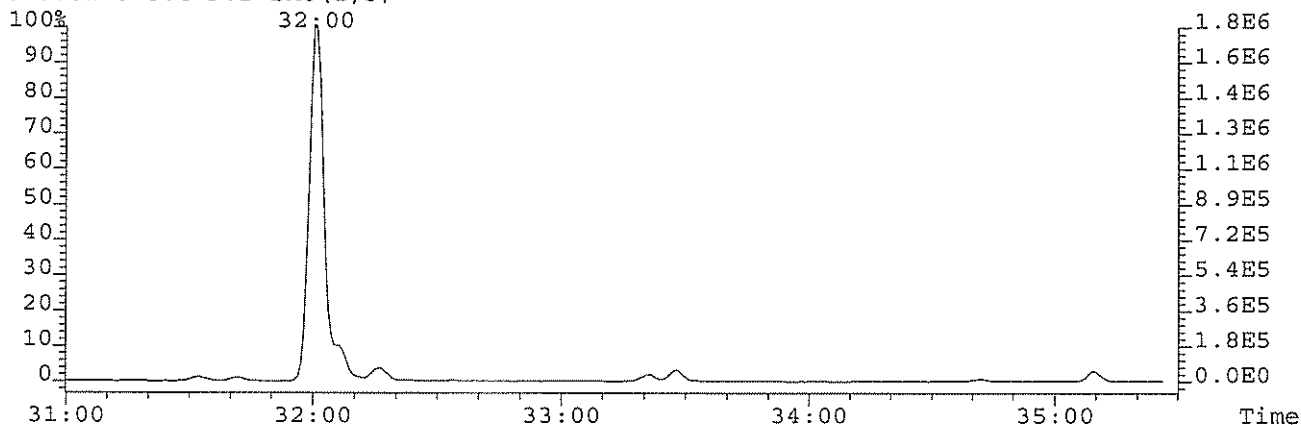
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130717 #1-649 Acq:17-JUL-2013 11:52:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:RH-12ms(5-8,nP) Text:XE13 0959 3 Exp:RH-PD22

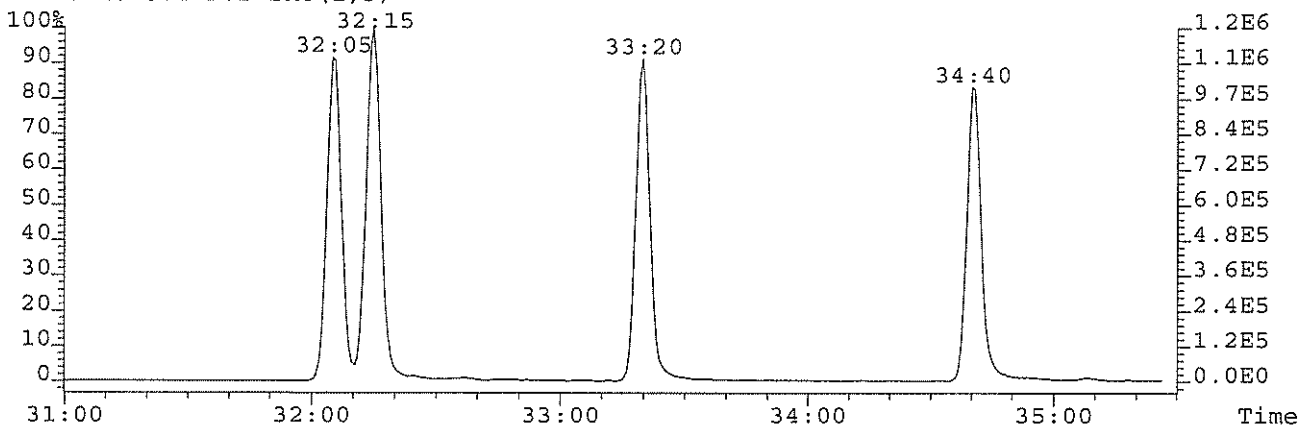
373.8207 S:4 F:2 SMO(1,3)



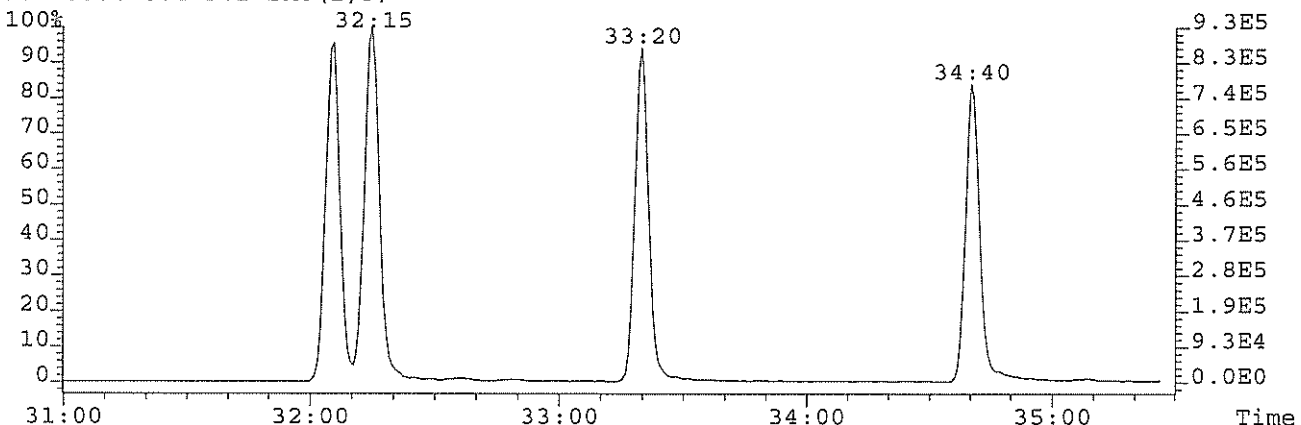
375.8178 S:4 F:2 SMO(1,3)



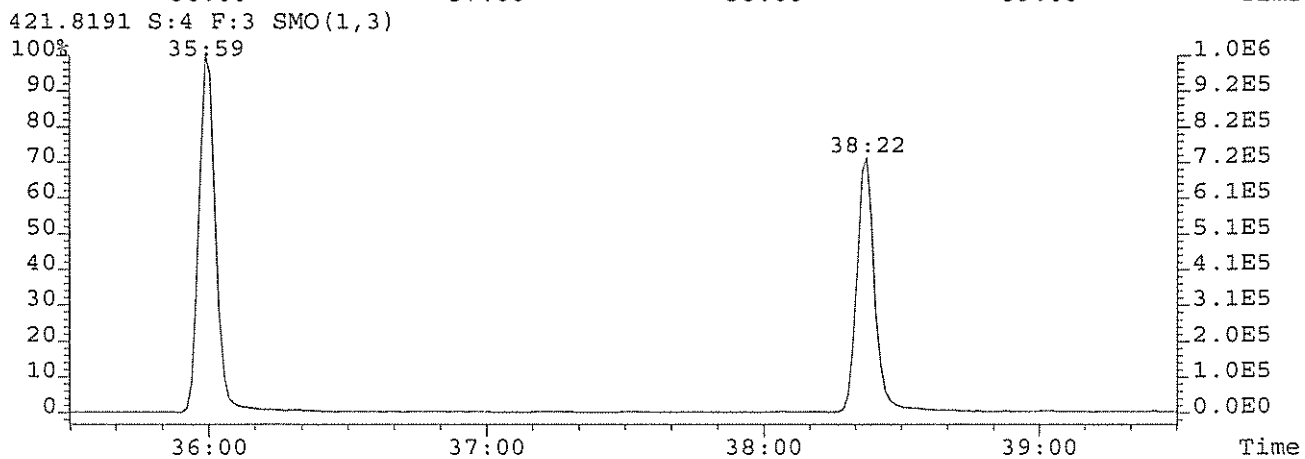
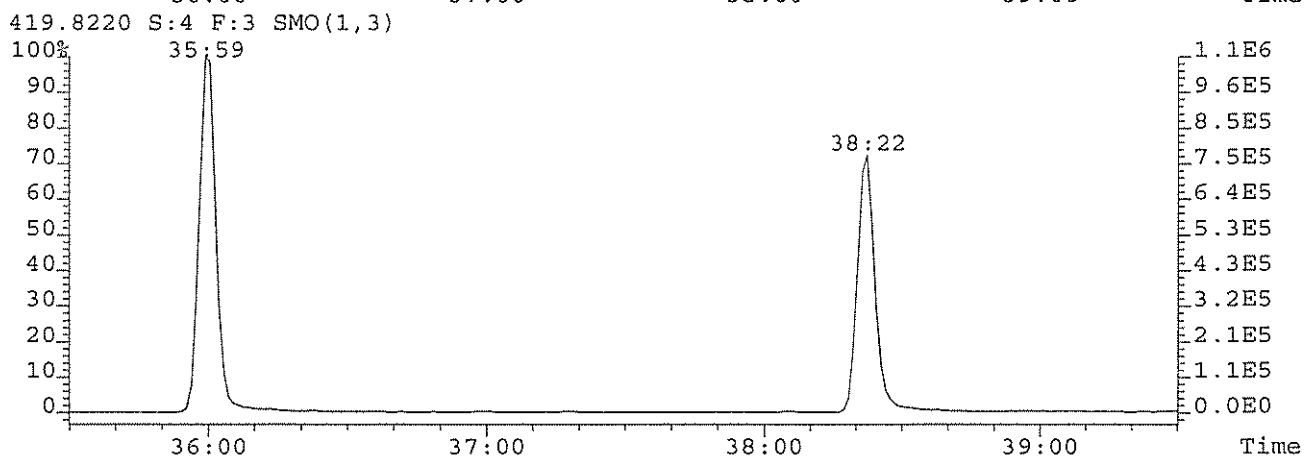
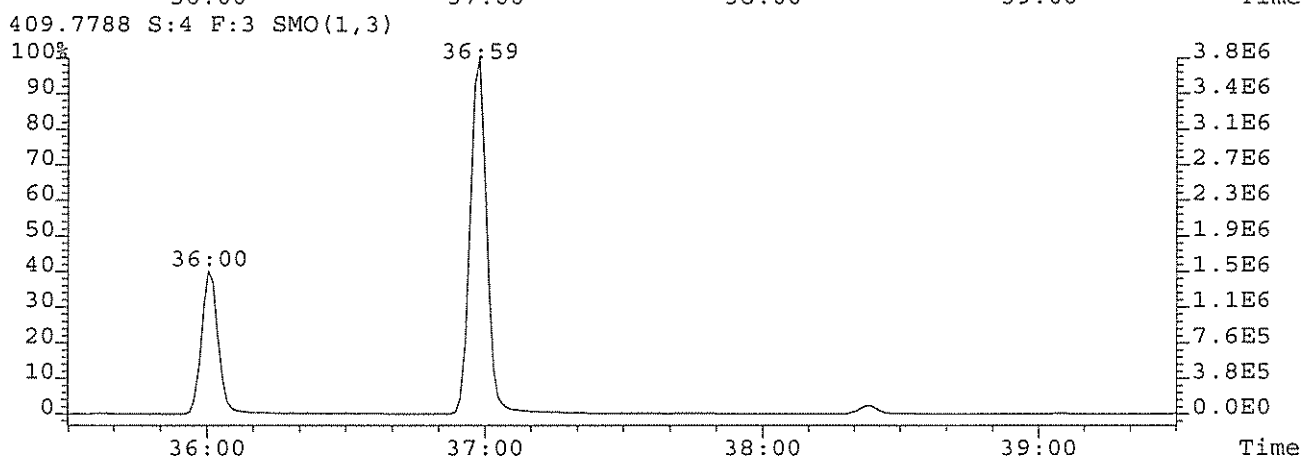
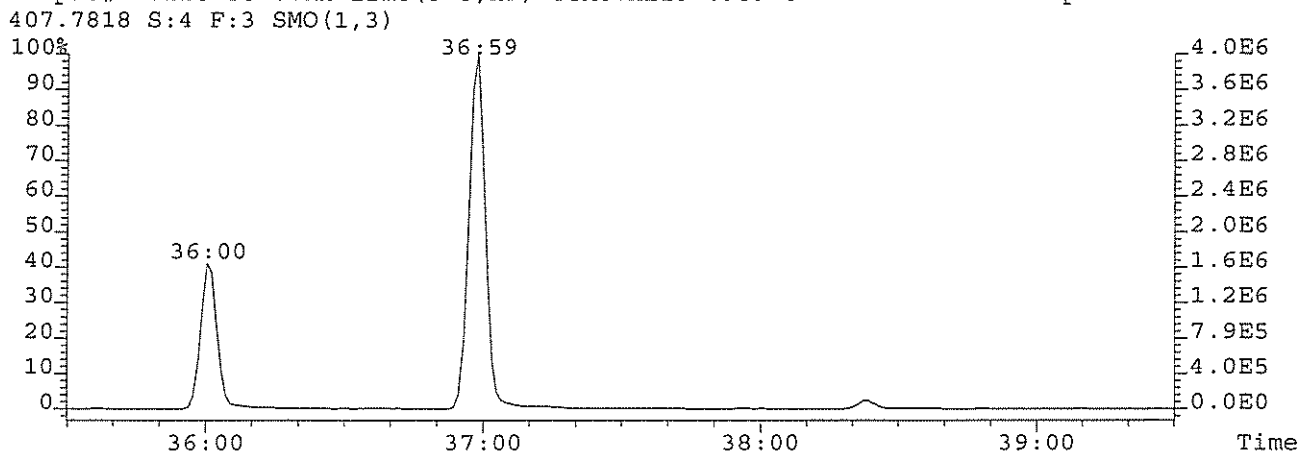
385.8610 S:4 F:2 SMO(1,3)



387.8580 S:4 F:2 SMO(1,3)



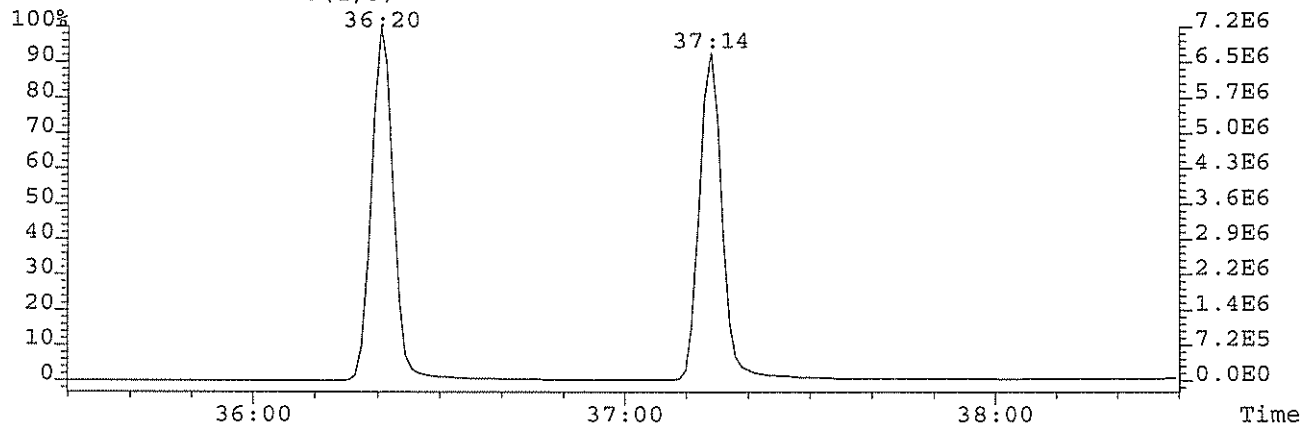
File:130717 #1-562 Acq:17-JUL-2013 11:52:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:RH-12ms(5-8,nP) Text:XE13 0959 3 Exp:RH-PD22



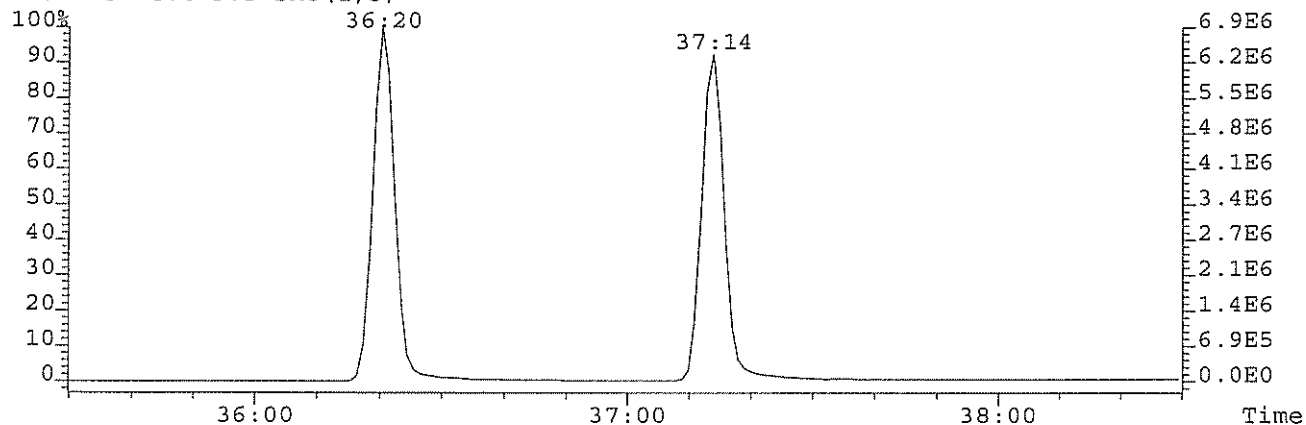
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130717 #1-562 Acq:17-JUL-2013 11:52:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:RH-12ms(5-8,nP) Text:XE13 0959 3 Exp:RH-PD22

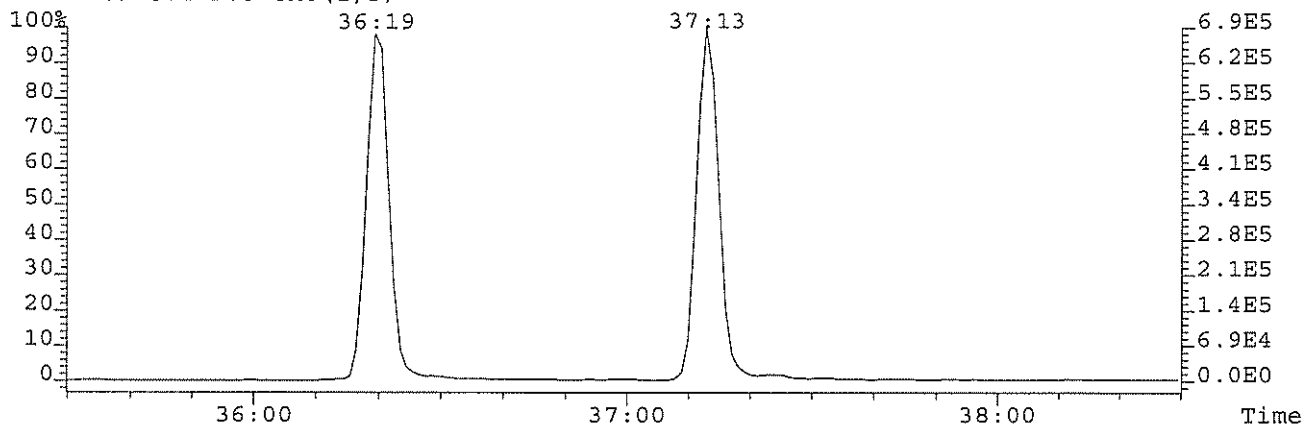
423.7767 S:4 F:3 SMO(1,3)



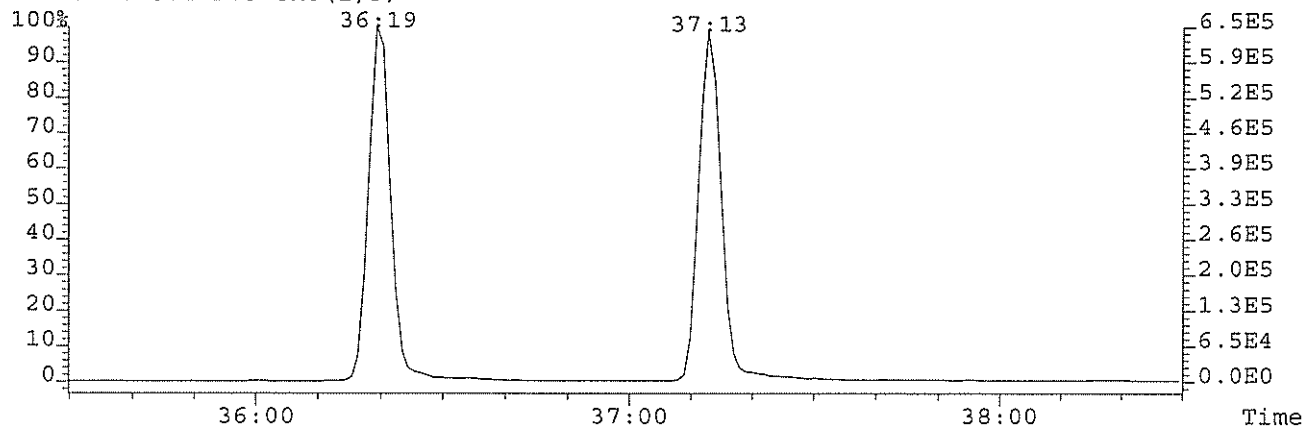
425.7737 S:4 F:3 SMO(1,3)



435.8169 S:4 F:3 SMO(1,3)



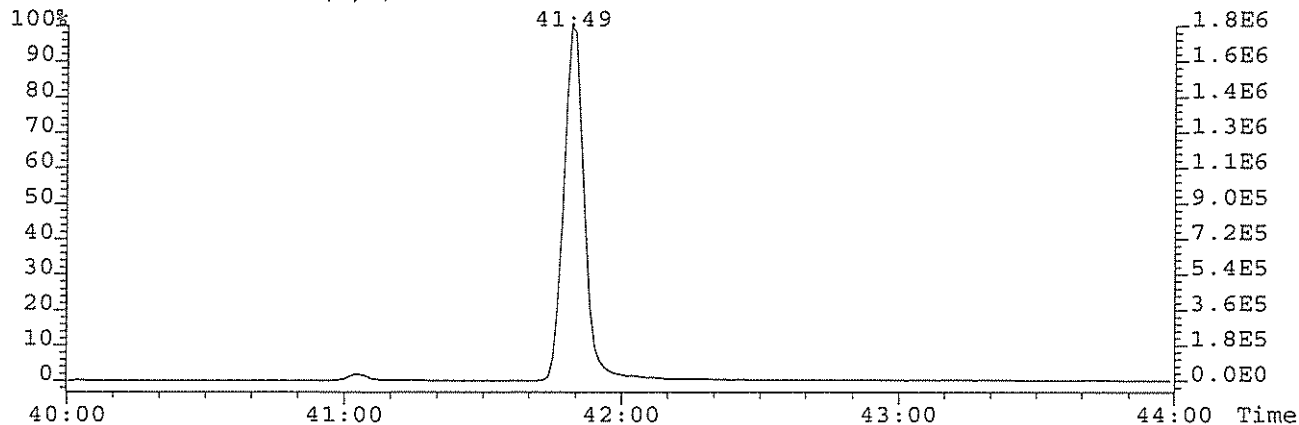
437.8140 S:4 F:3 SMO(1,3)



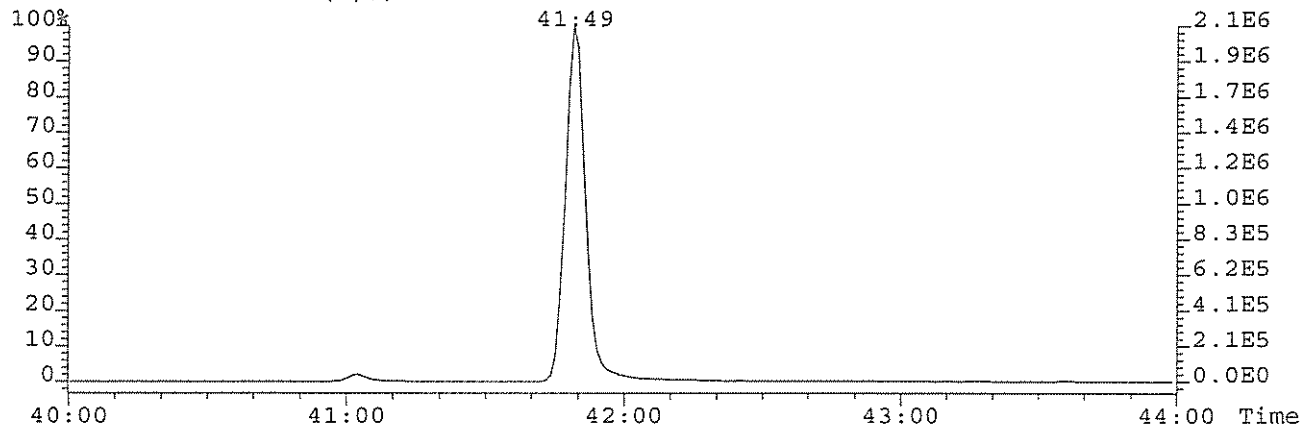
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130717 #1-562 Acq:17-JUL-2013 11:52:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:RH-12ms(5-8,nP) Text:XE13 0959 3 Exp:RH-PD22

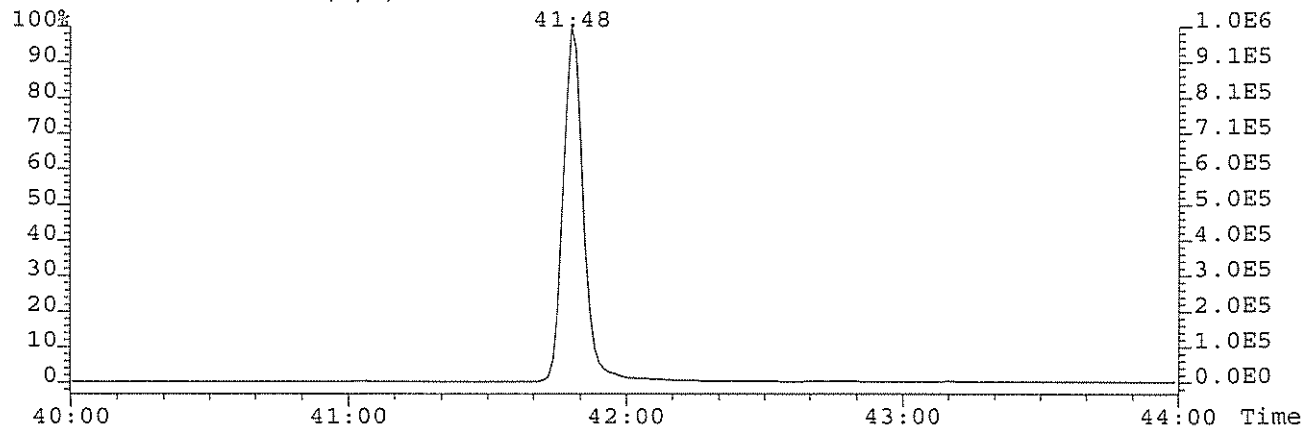
441.7428 S:4 F:3 SMO(1,3)



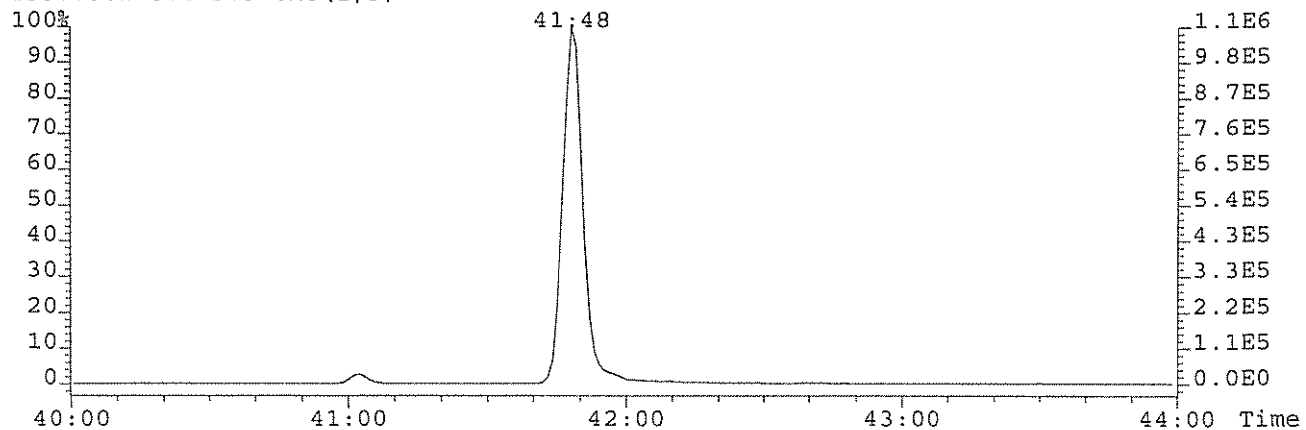
443.7398 S:4 F:3 SMO(1,3)



453.7830 S:4 F:3 SMO(1,3)



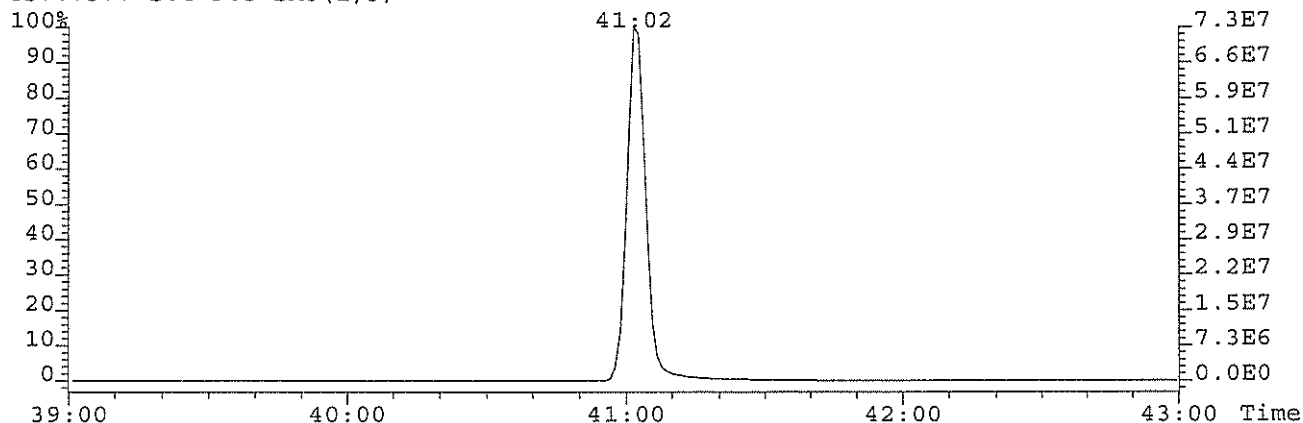
455.7801 S:4 F:3 SMO(1,3)



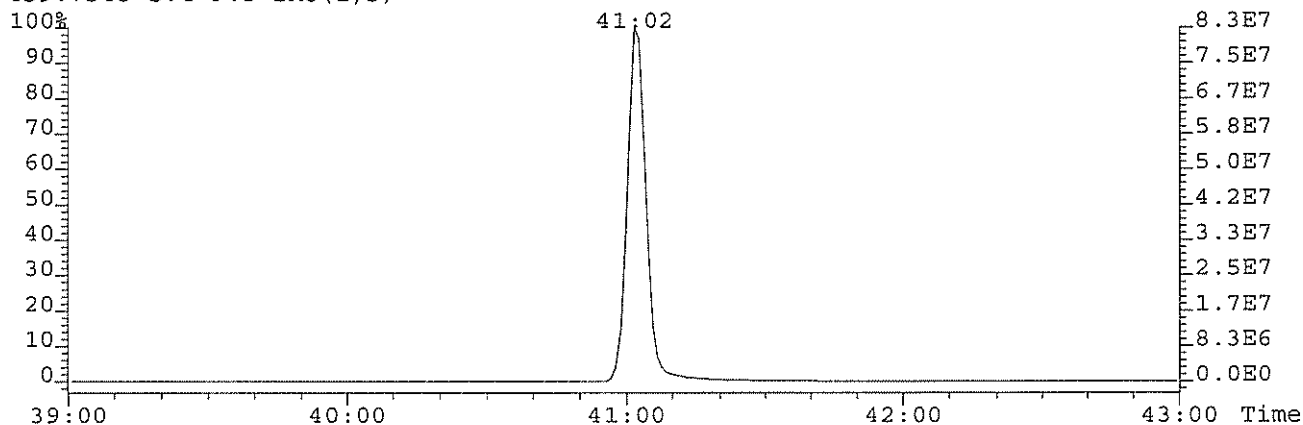
PCDFsクロマトグラム (11)  
(OCDF)

File:130717 #1-562 Acq:17-JUL-2013 11:52:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:RH-12ms(5-8,nP) Text:XE13 0959 3 Exp:RH-PD22

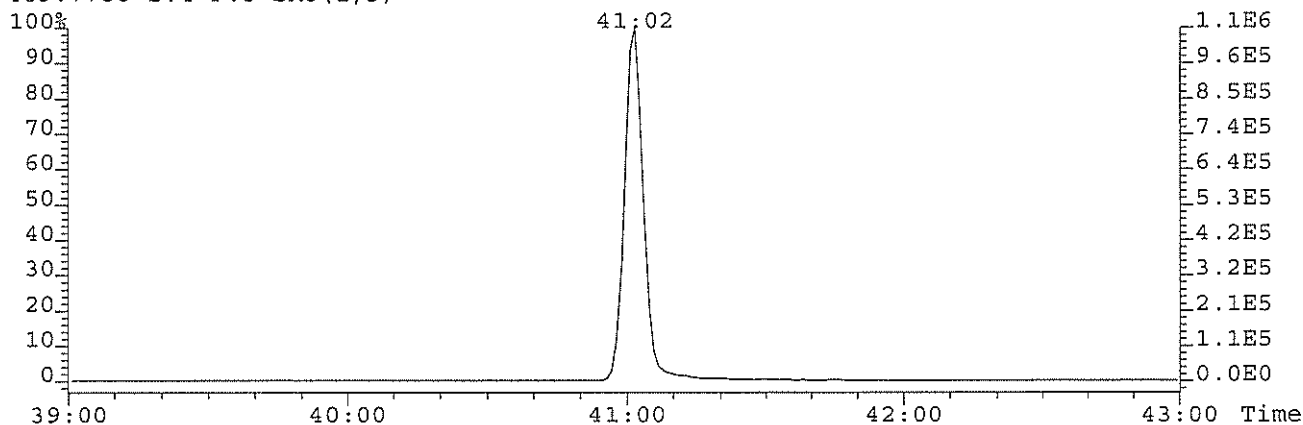
457.7377 S:4 F:3 SMO(1,3)



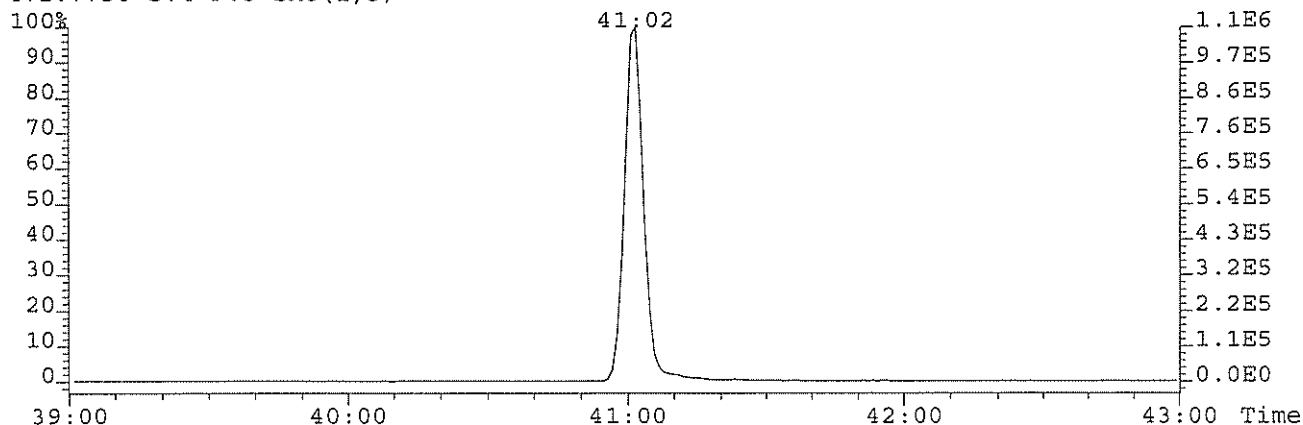
459.7348 S:4 F:3 SMO(1,3)



469.7780 S:4 F:3 SMO(1,3)



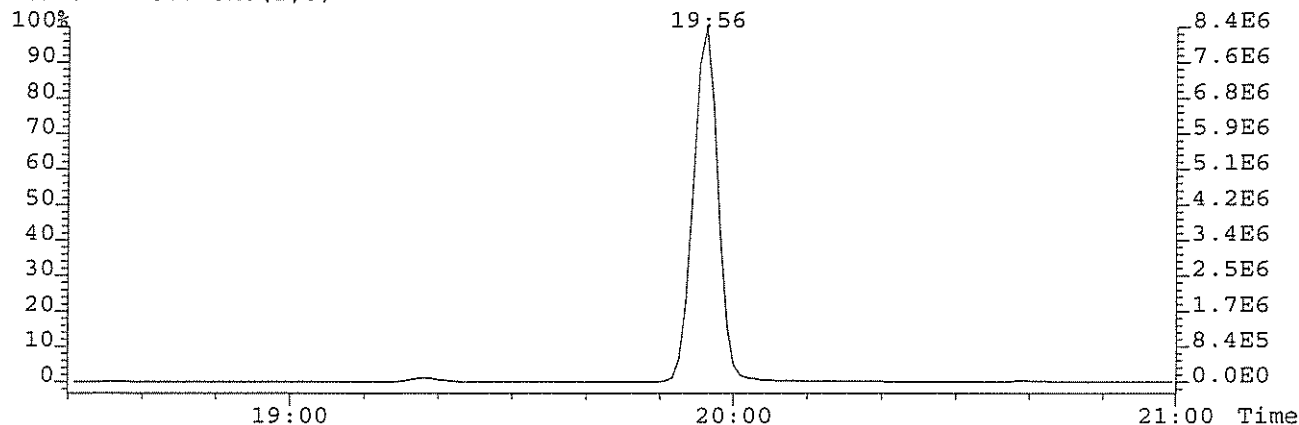
471.7750 S:4 F:3 SMO(1,3)



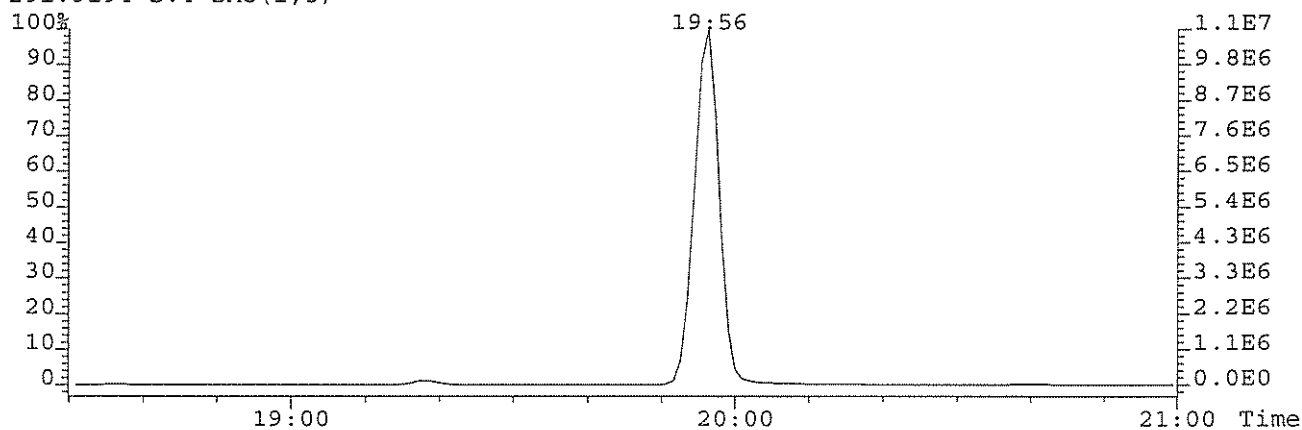
PCDDsクロマトグラム (12)  
(OCDD)

File:130717 #1-1430 Acq:17-JUL-2013 11:52:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:RH-12ms(5-8,nP) Text:XE13 0959 3 Exp:RH-PD22

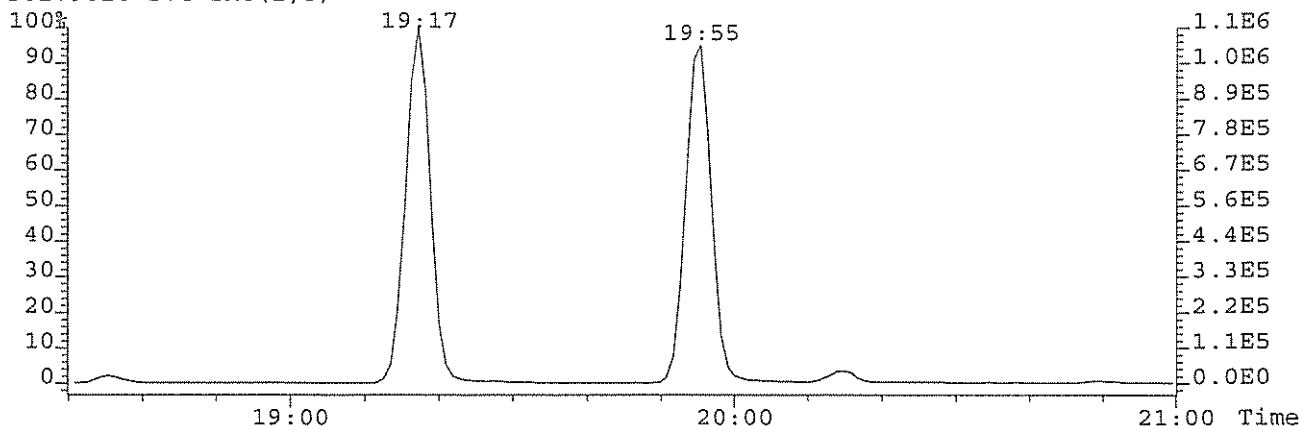
289.9224 S:4 SMO(1,3)



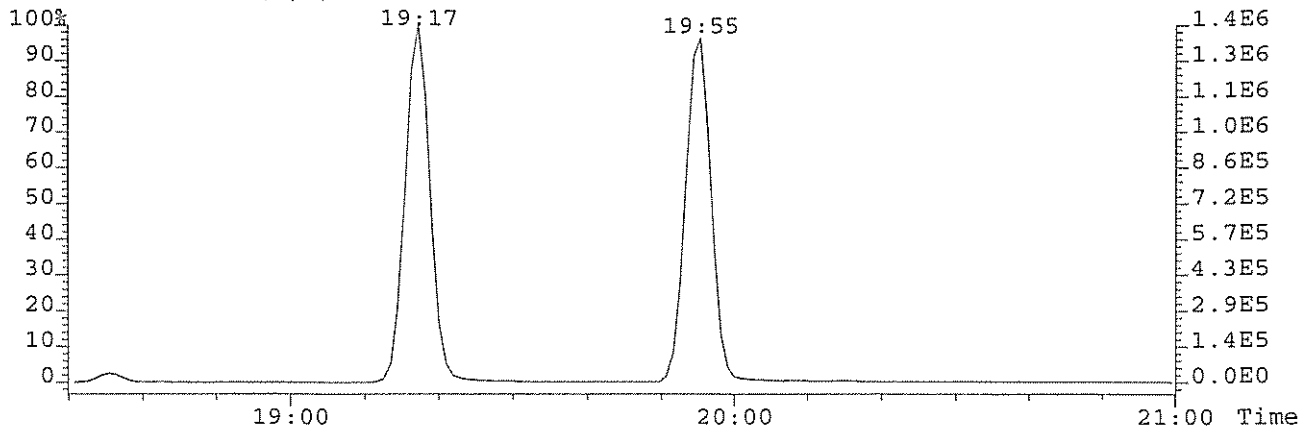
291.9194 S:4 SMO(1,3)



301.9626 S:4 SMO(1,3)



303.9597 S:4 SMO(1,3)

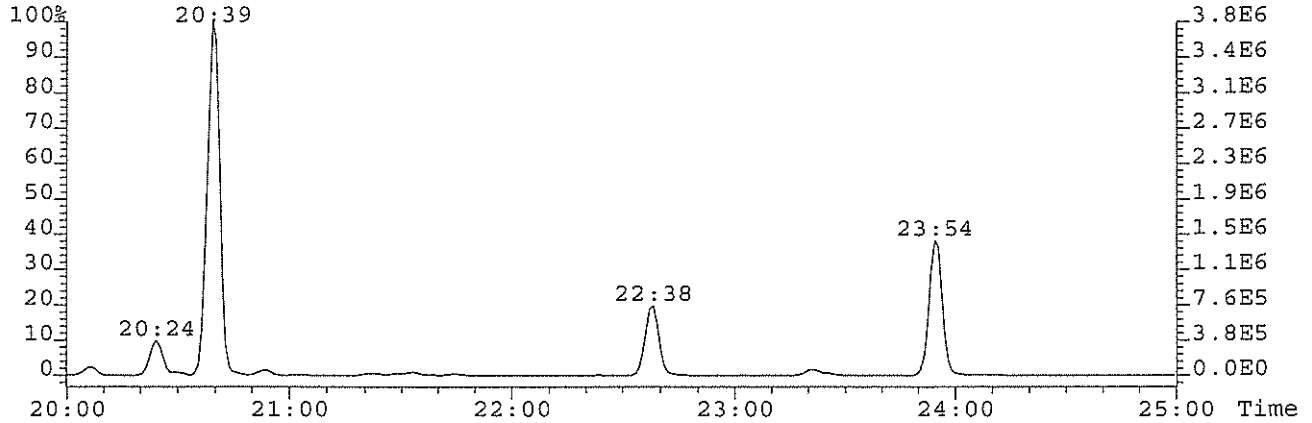


DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

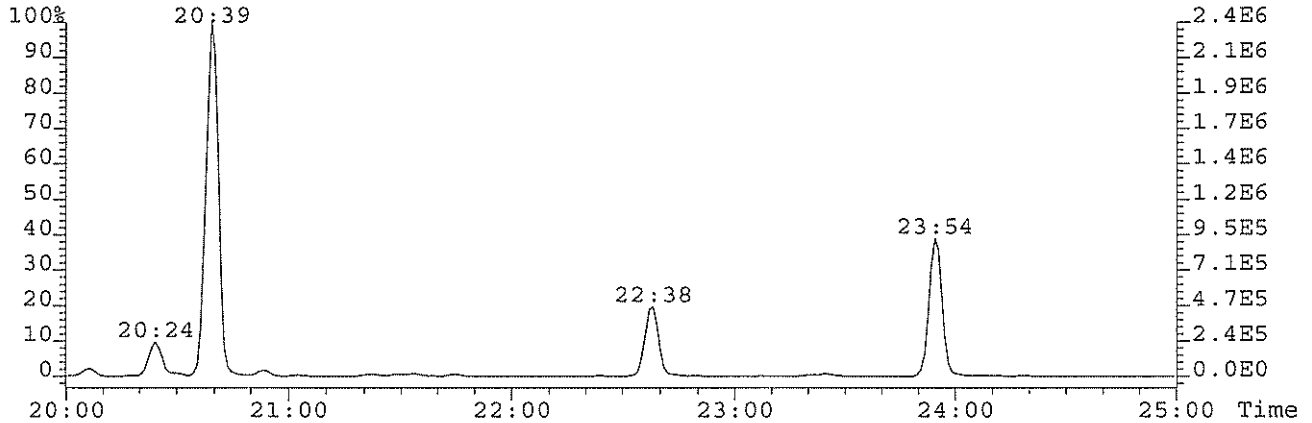


File:130717 #1-1430 Acq:17-JUL-2013 11:52:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:RH-12ms(5-8,nP) Text:XE13 0959 3 Exp:RH-PD22

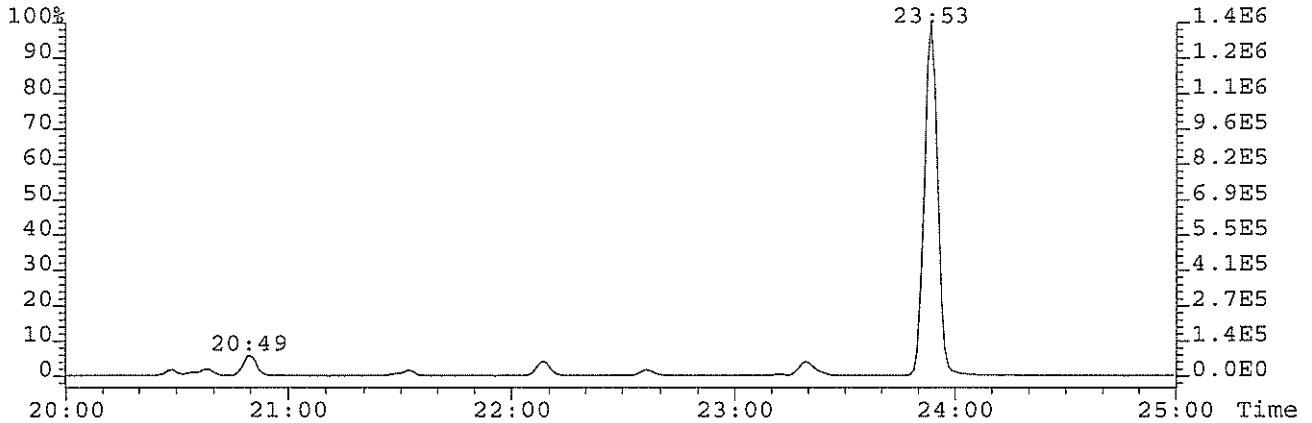
325.8804 S:4 SMO(1,3)



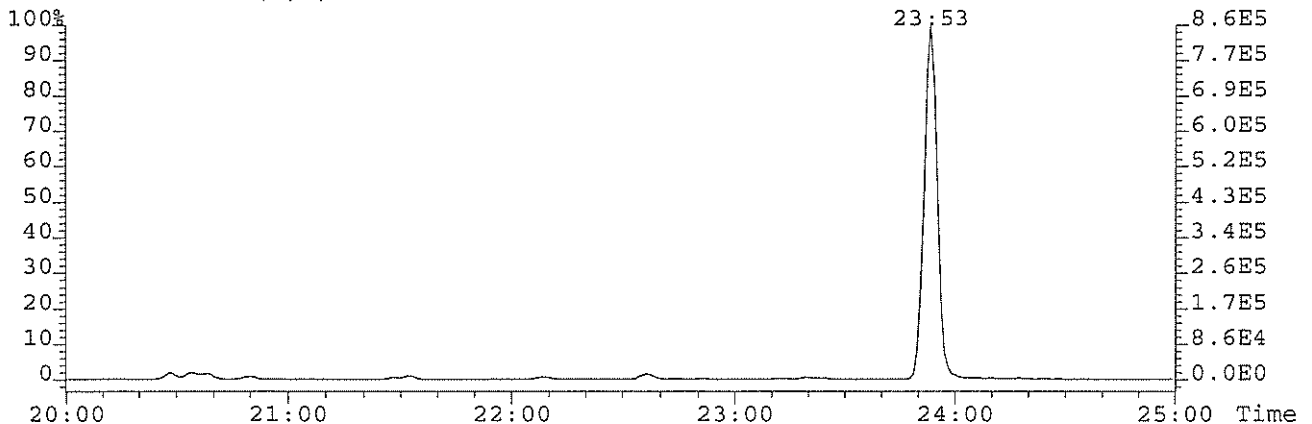
327.8775 S:4 SMO(1,3)



337.9207 S:4 SMO(1,3)

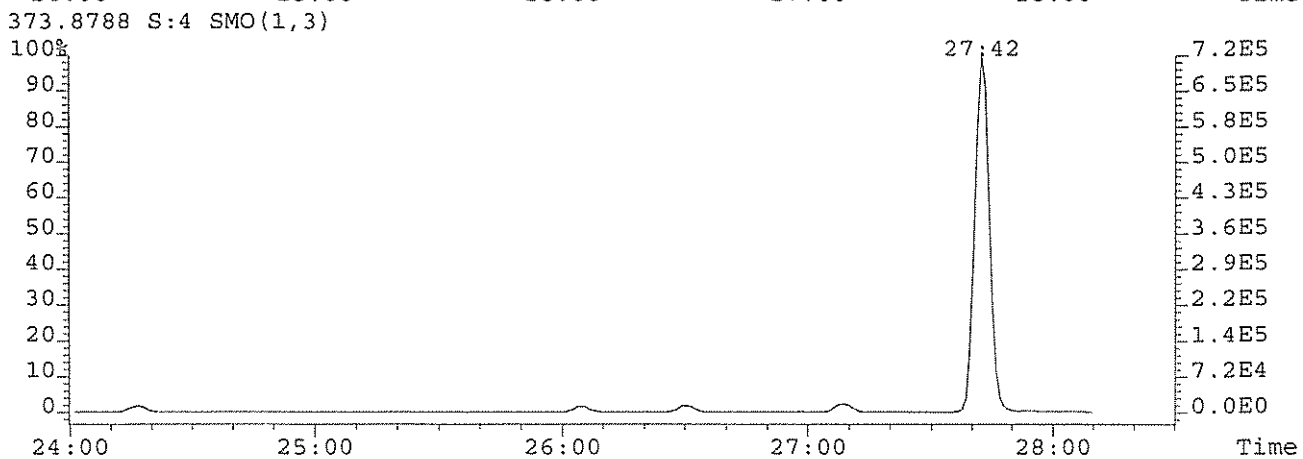
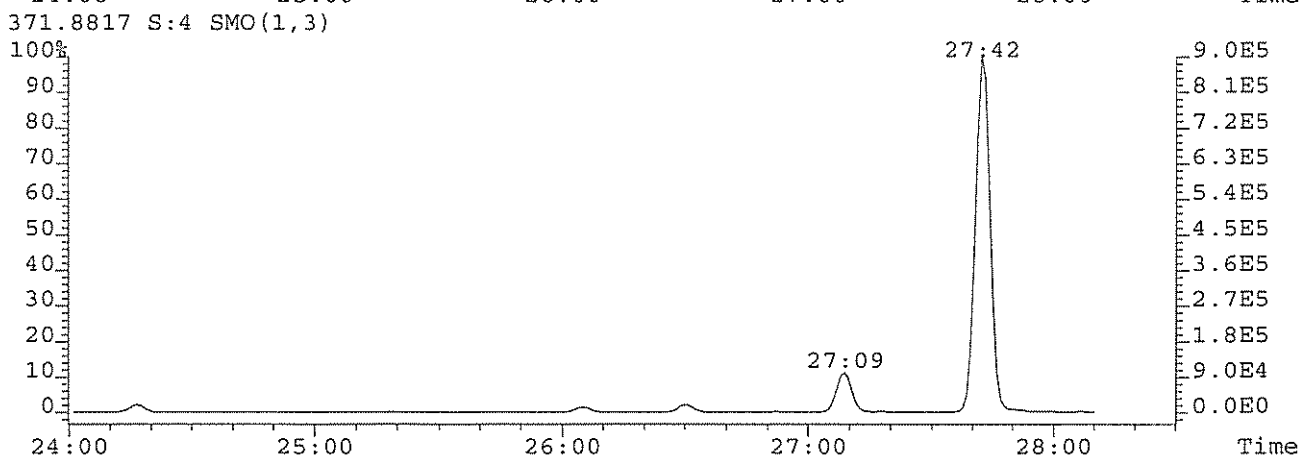
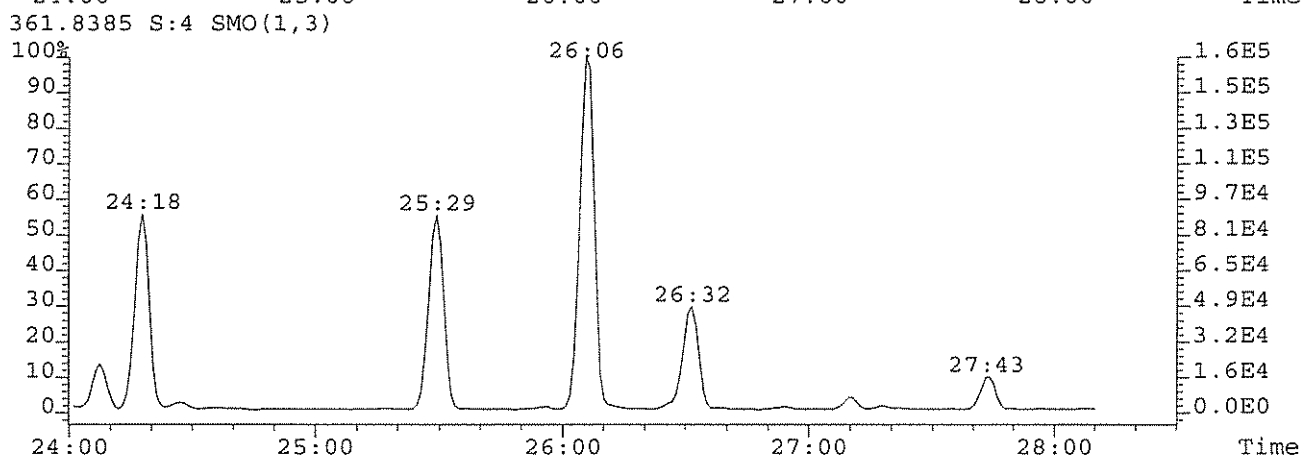
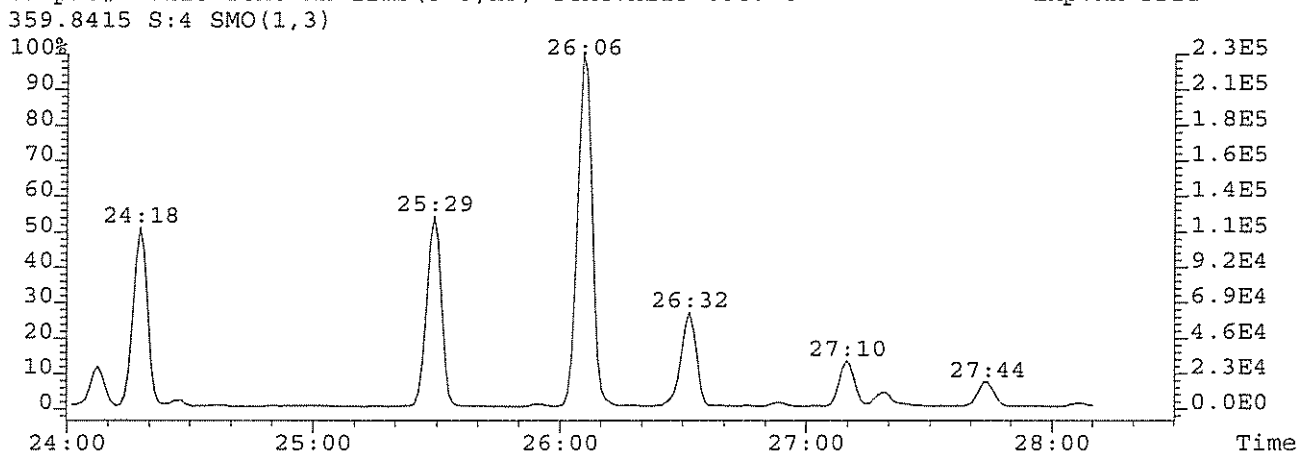


339.9178 S:4 SMO(1,3)



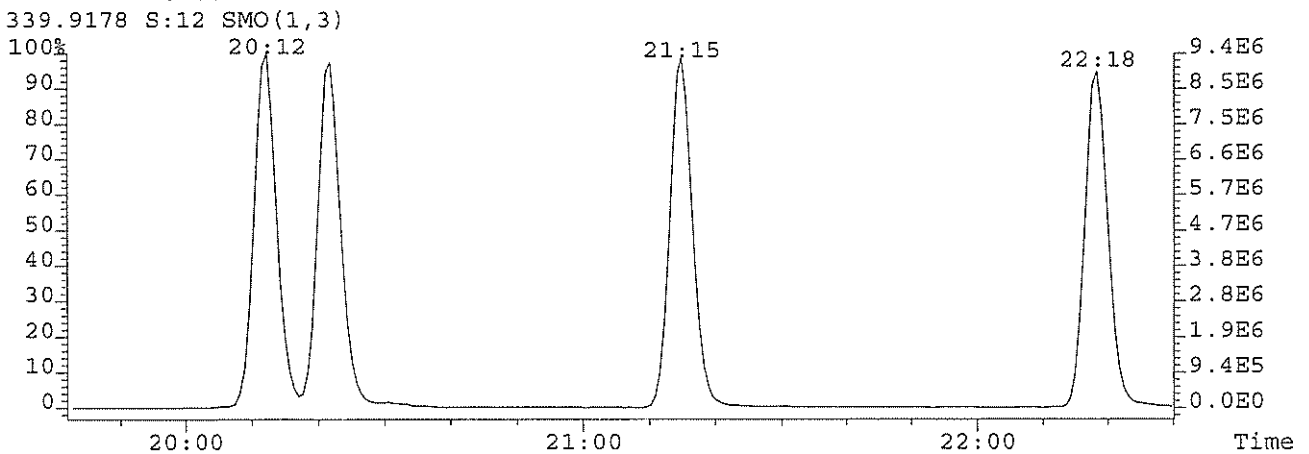
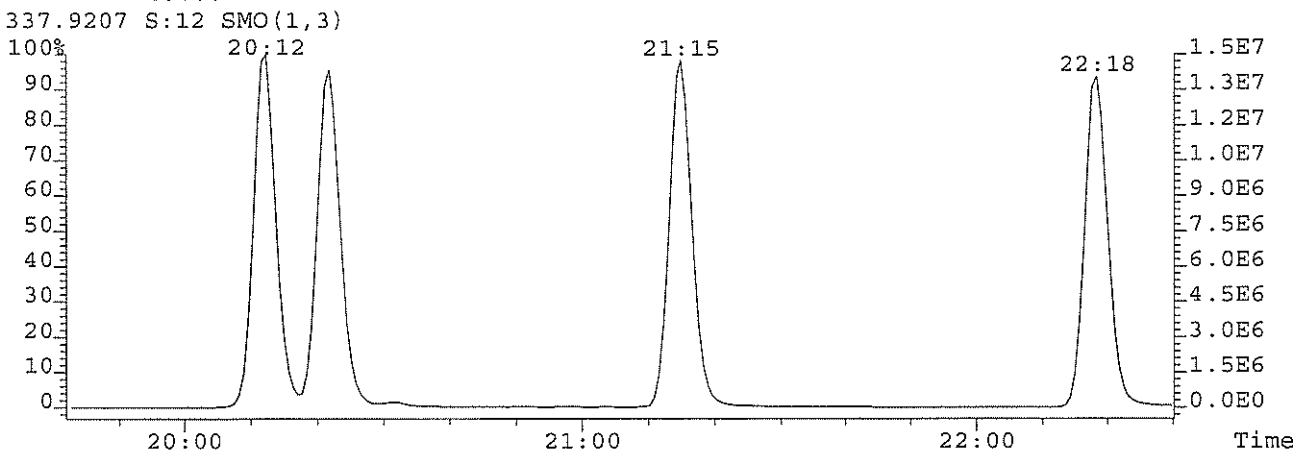
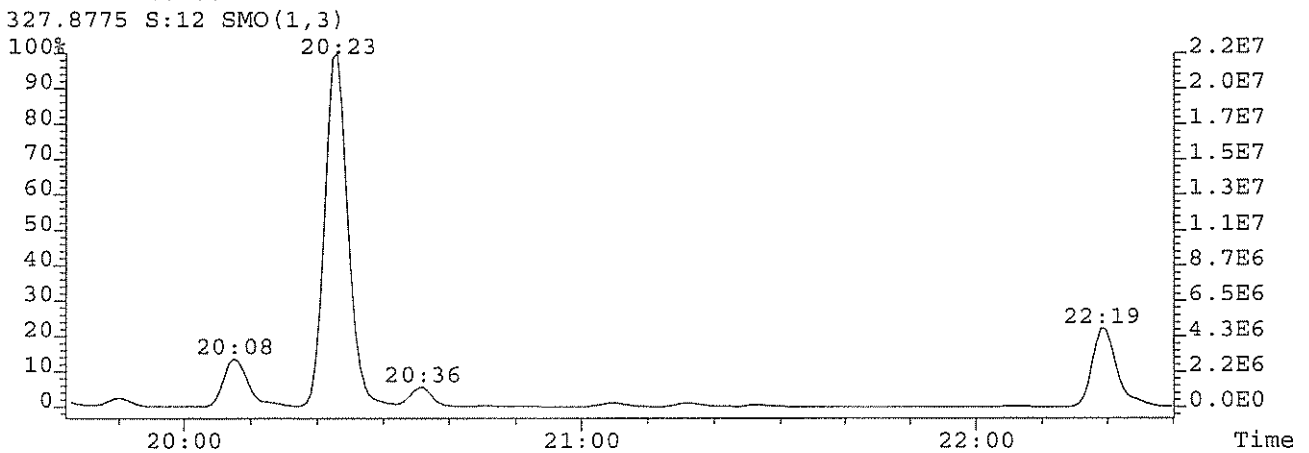
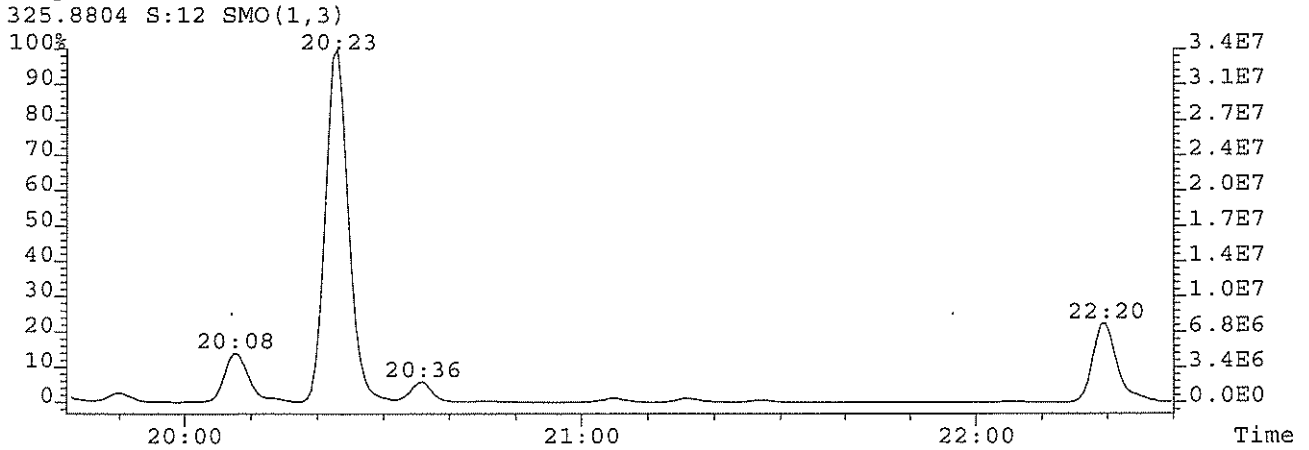
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130717 #1-1430 Acq:17-JUL-2013 11:52:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#4 File Text:RH-12ms(5-8,nP) Text:XE13 0959 3 Exp:RH-PD22



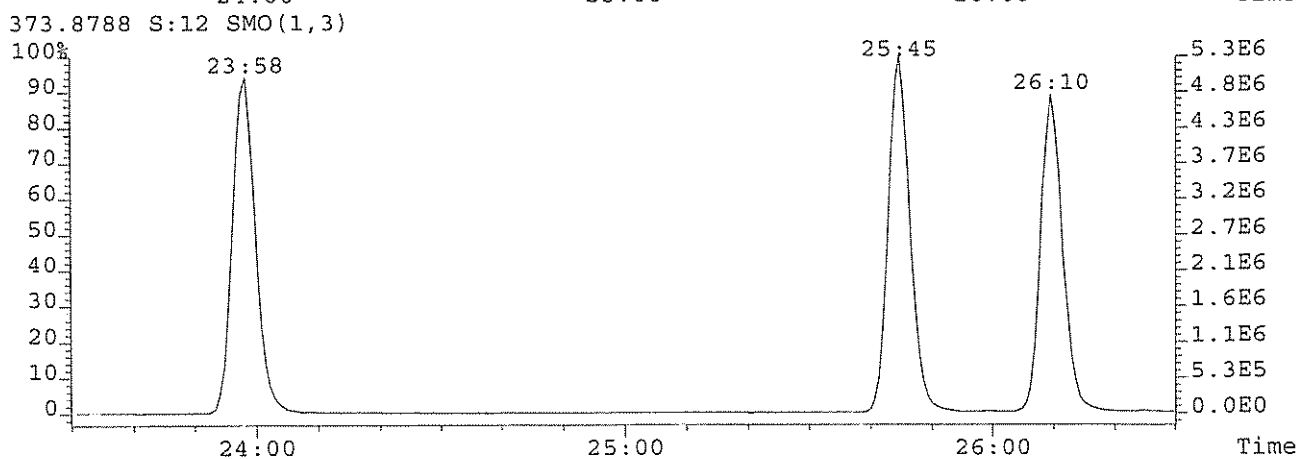
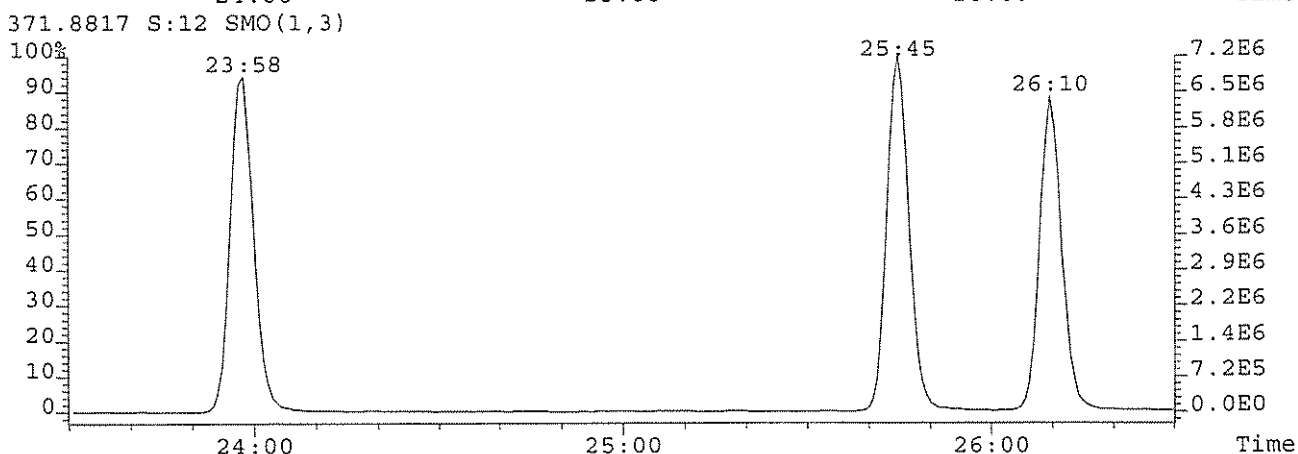
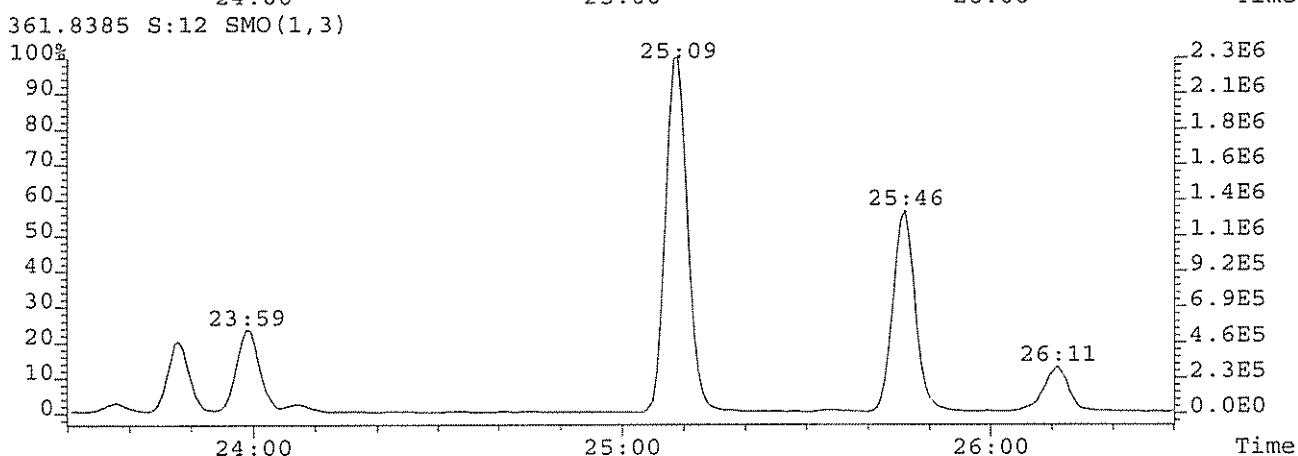
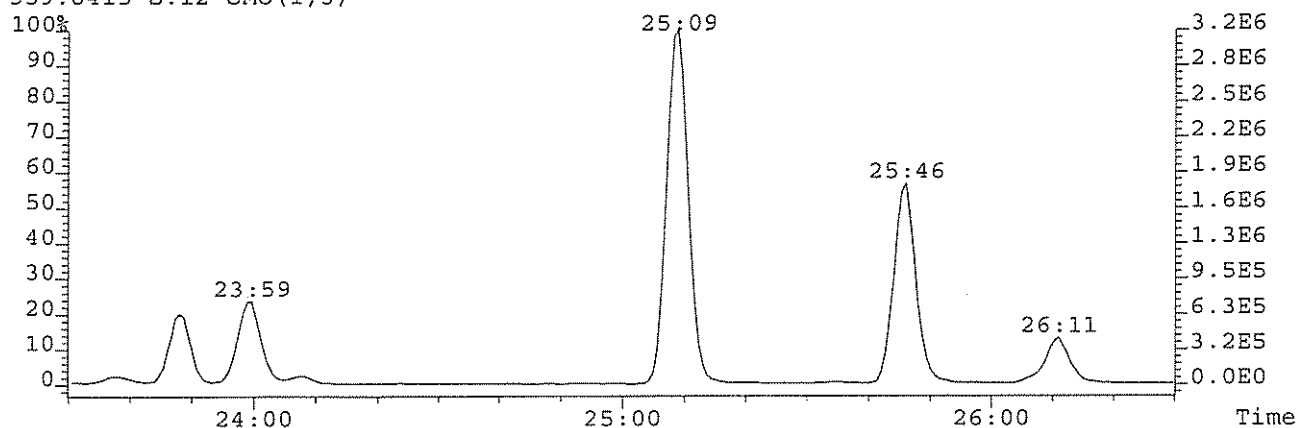
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130713 #1-2897 Acq:13-JUL-2013 19:34:59 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#12 File Text:RH-12ms(mP) Text:XE13 0959 2 1/100 Exp:RH-MP11



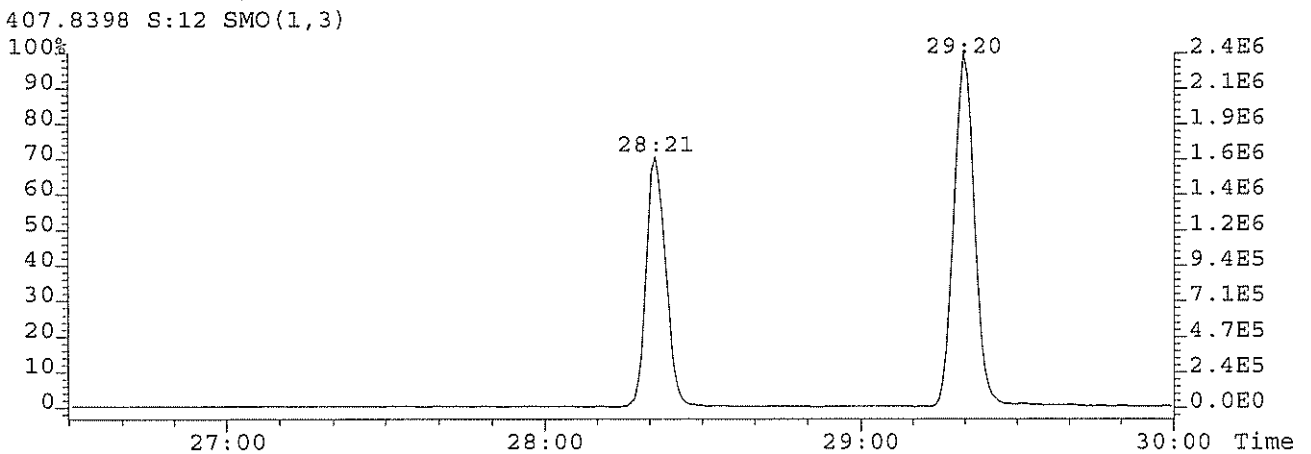
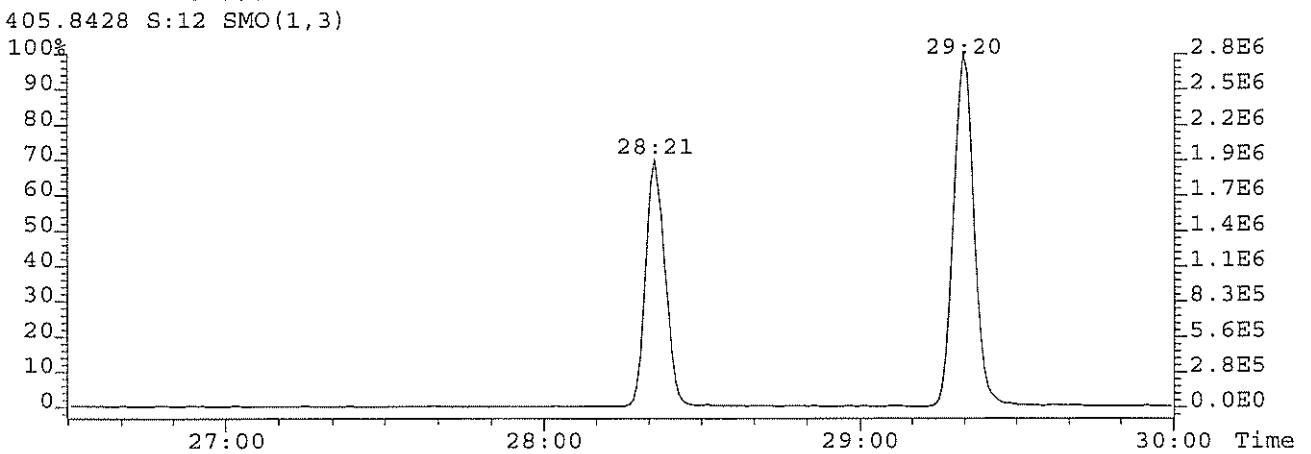
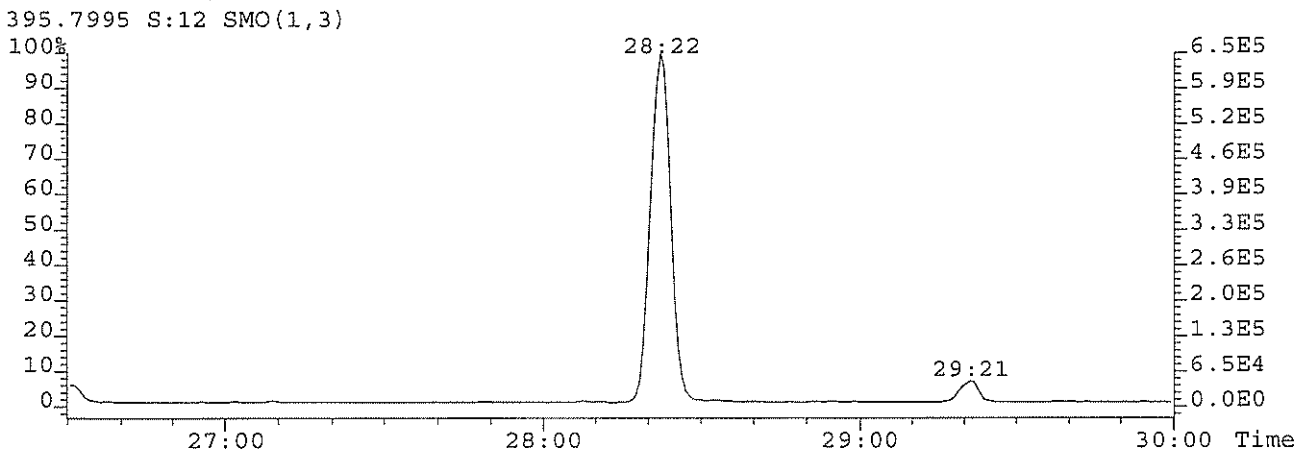
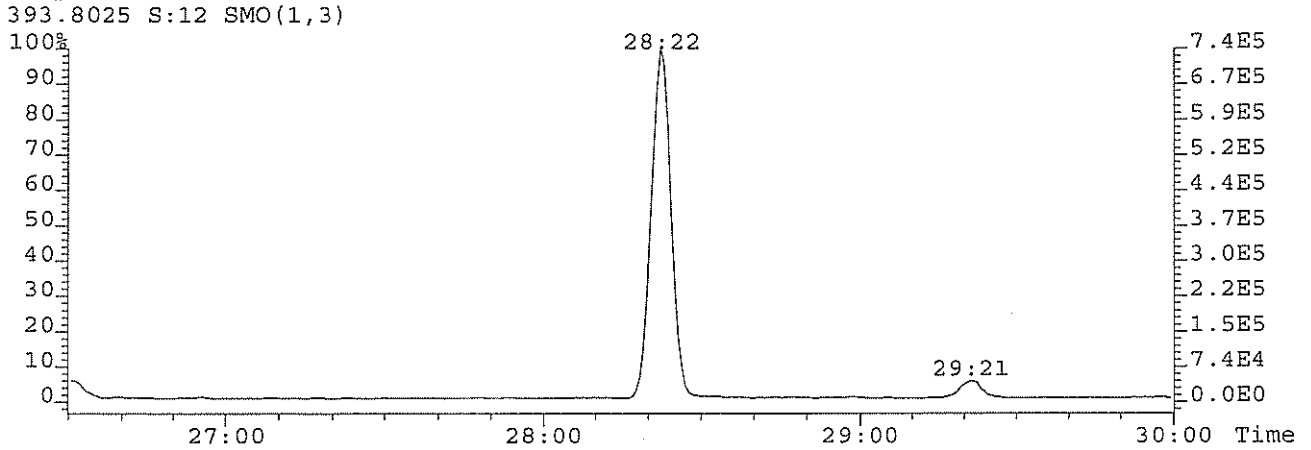
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130713 #1-2897 Acq:13-JUL-2013 19:34:59 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#12 File Text:RH-12ms(mP) Text:XE13 0959 2 1/100 Exp:RH-MP11  
359.8415 S:12 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

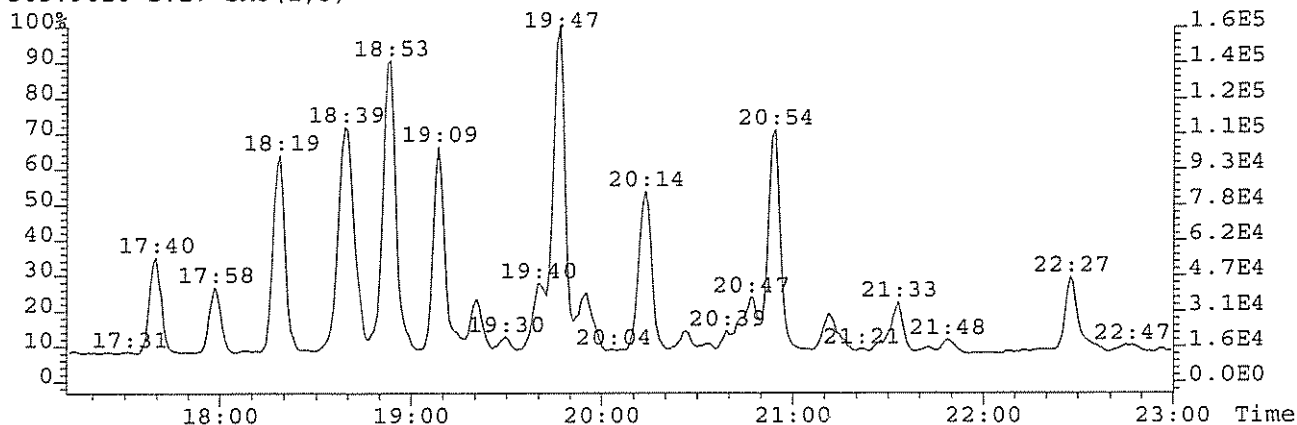
File:130713 #1-2897 Acq:13-JUL-2013 19:34:59 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#12 File Text:RH-12ms(mP) Text:XE13 0959 2 1/100 Exp:RH-MP11



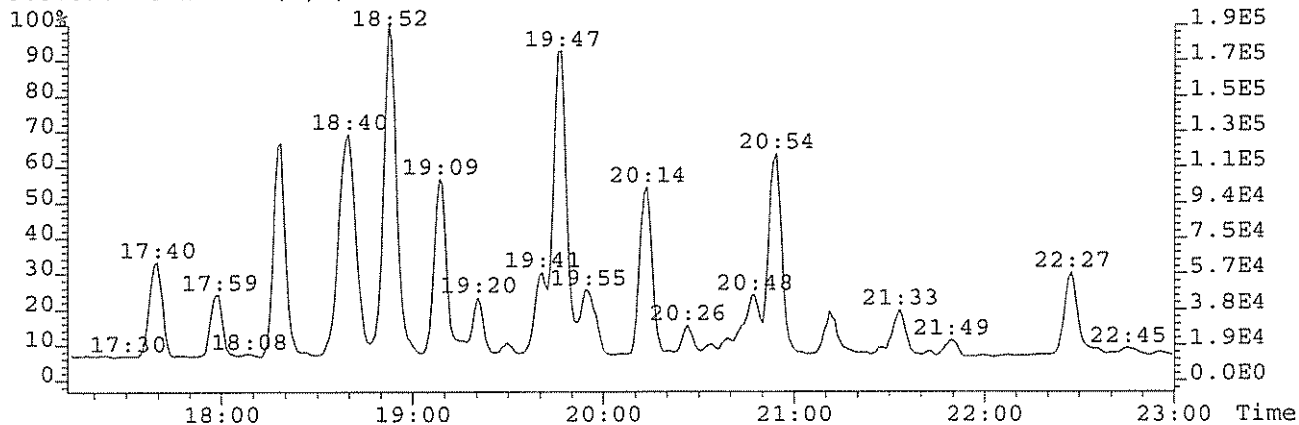
DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

試料管理番号	XE 130960
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.14

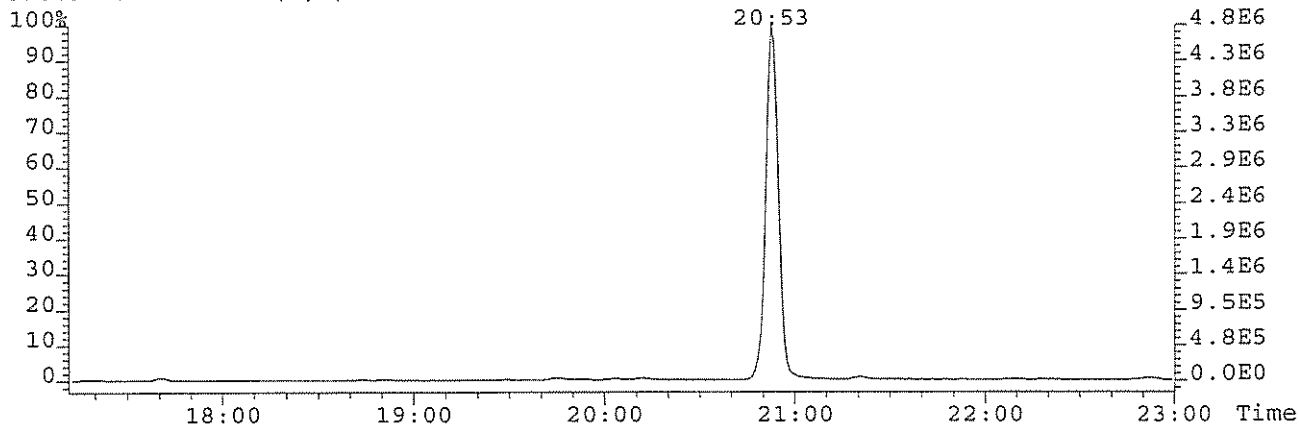
File:130712-2 #1-1577 Acq:13-JUL-2013 05:05:49 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:BPX-DXN(4-6DXN) Text:XE13 0960 Exp:BPX04  
303.9016 S:17 SMO(1,3)



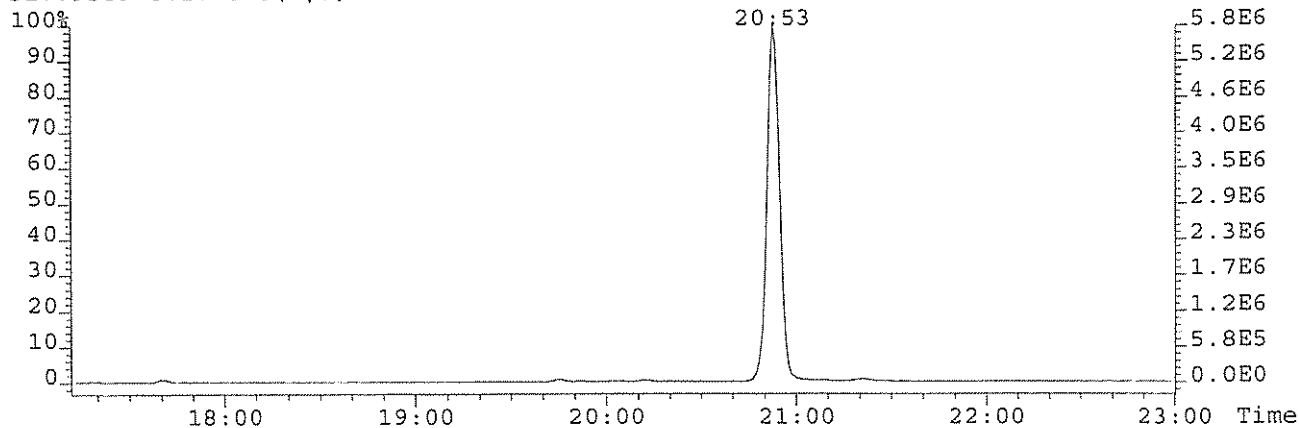
305.8987 S:17 SMO(1,3)



315.9419 S:17 SMO(1,3)



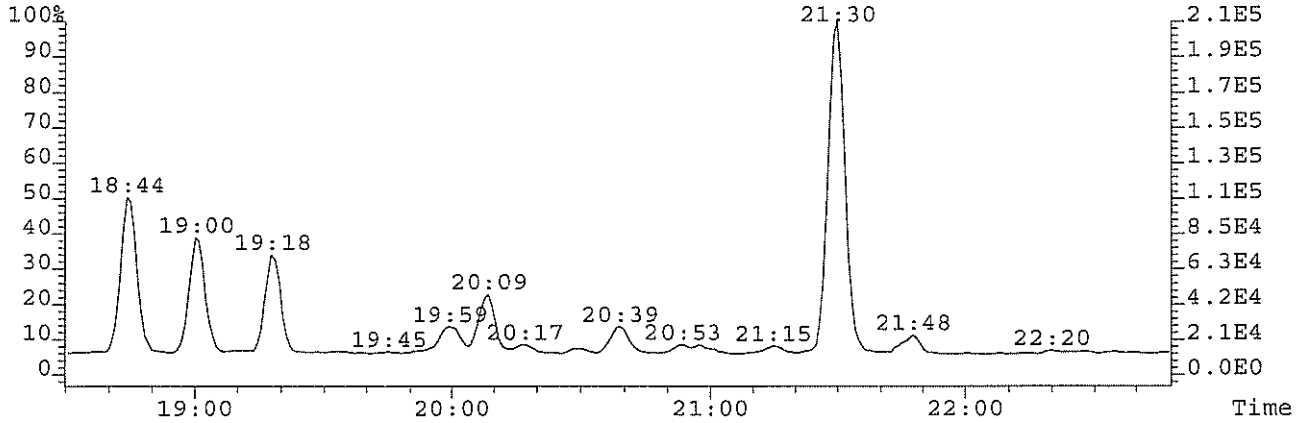
317.9389 S:17 SMO(1,3)



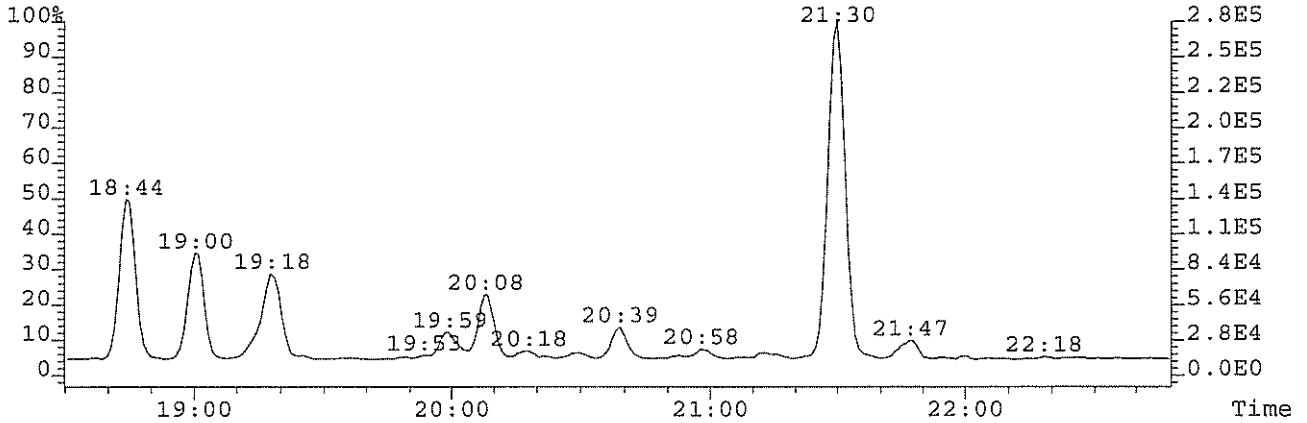
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130712-2 #1-1577 Acq:13-JUL-2013 05:05:49 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:BPX-DXN(4-6DXN) Text:XE13 0960 Exp:BPX04

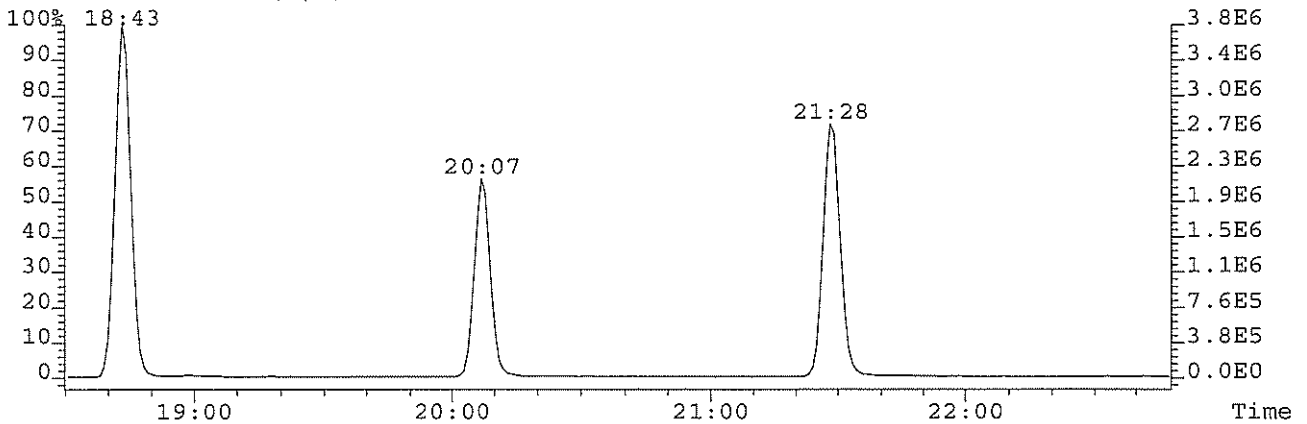
319.8965 S:17 SMO(1,3)



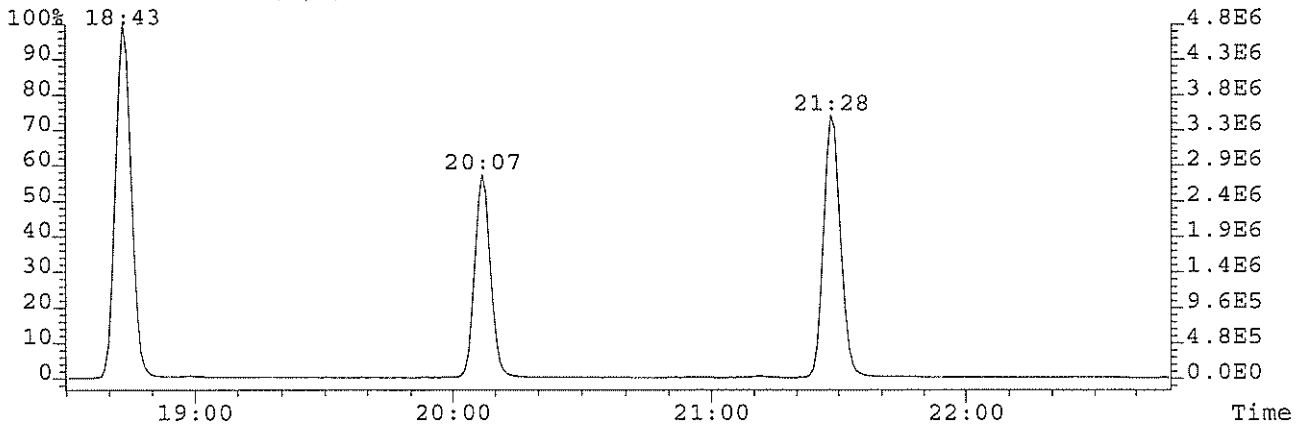
321.8936 S:17 SMO(1,3)



331.9368 S:17 SMO(1,3)



333.9339 S:17 SMO(1,3)

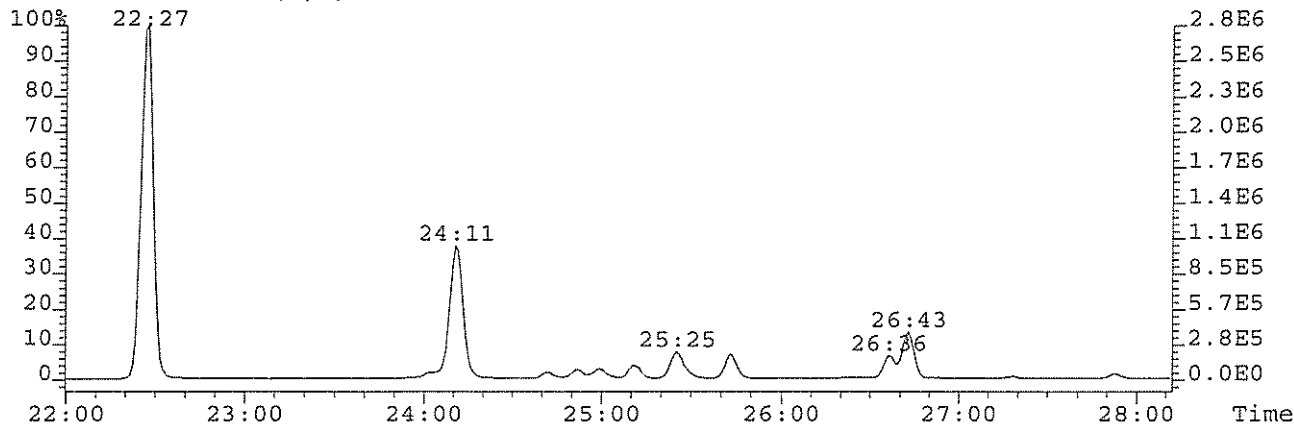


PCDDsクロマトグラム (2)  
(TeCDDs)

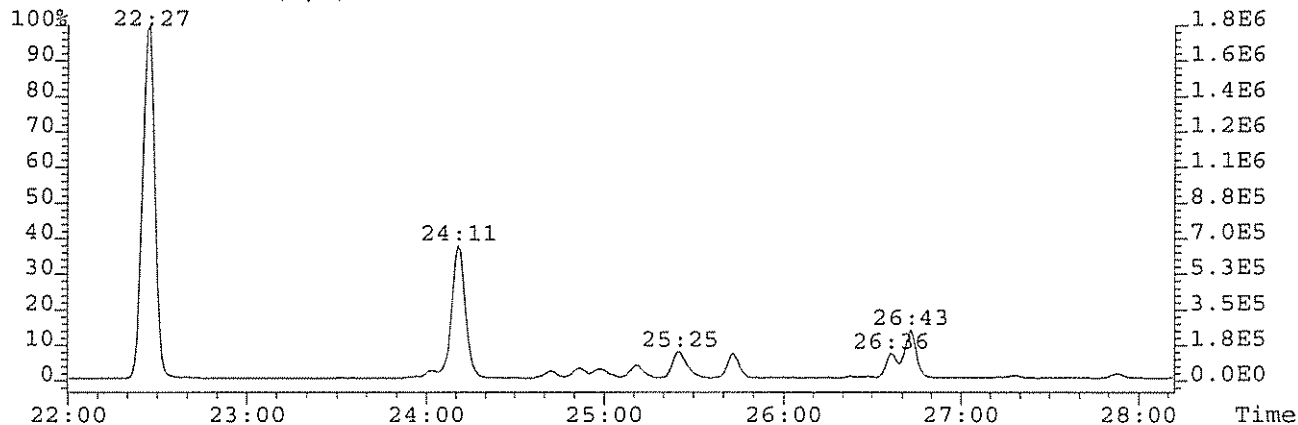


File:130712-2 #1-1577 Acq:13-JUL-2013 05:05:49 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:BPX-DXN(4-6DXN) Text:XE13 0960 Exp:BPX04

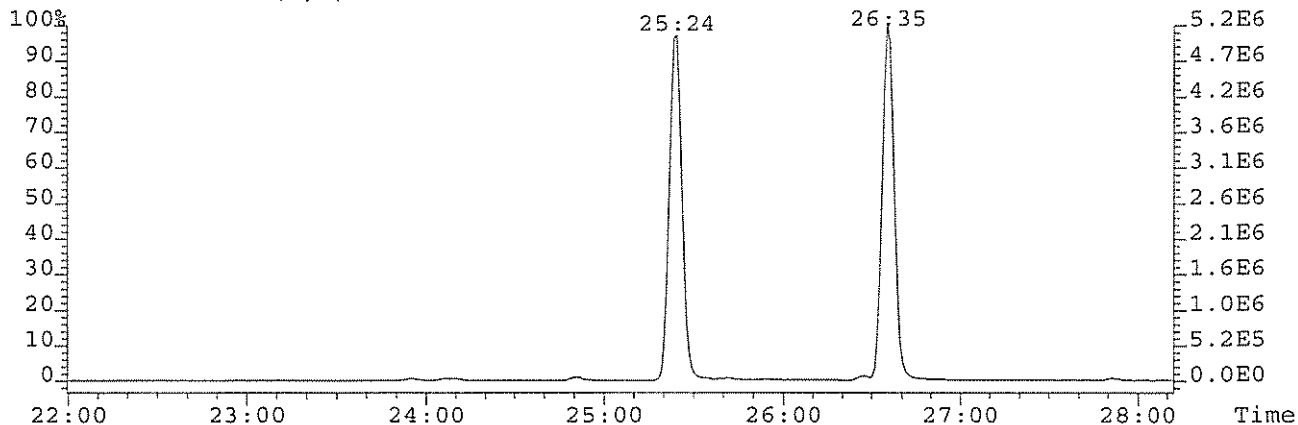
339.8597 S:17 SMO(1,3)



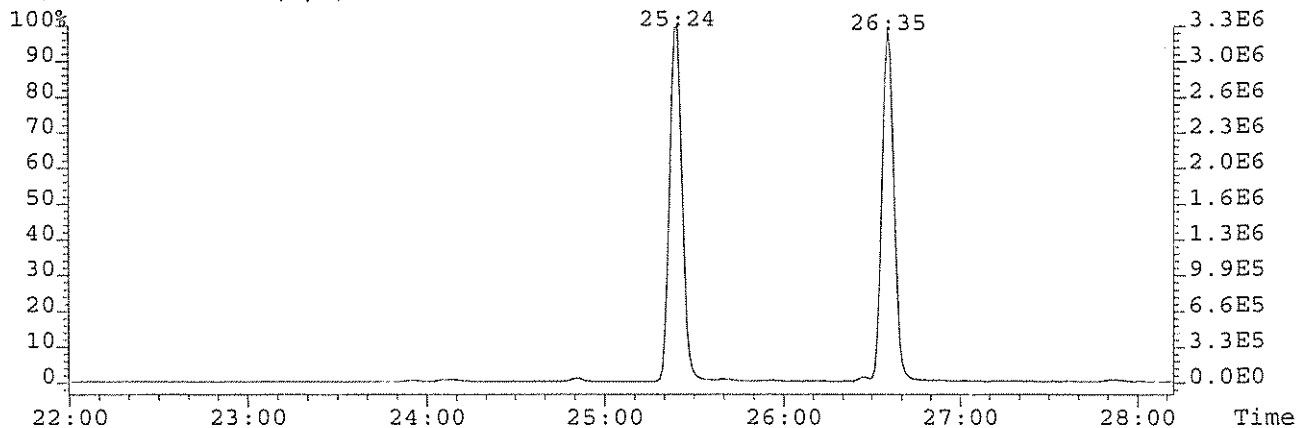
341.8568 S:17 SMO(1,3)



351.9000 S:17 SMO(1,3)

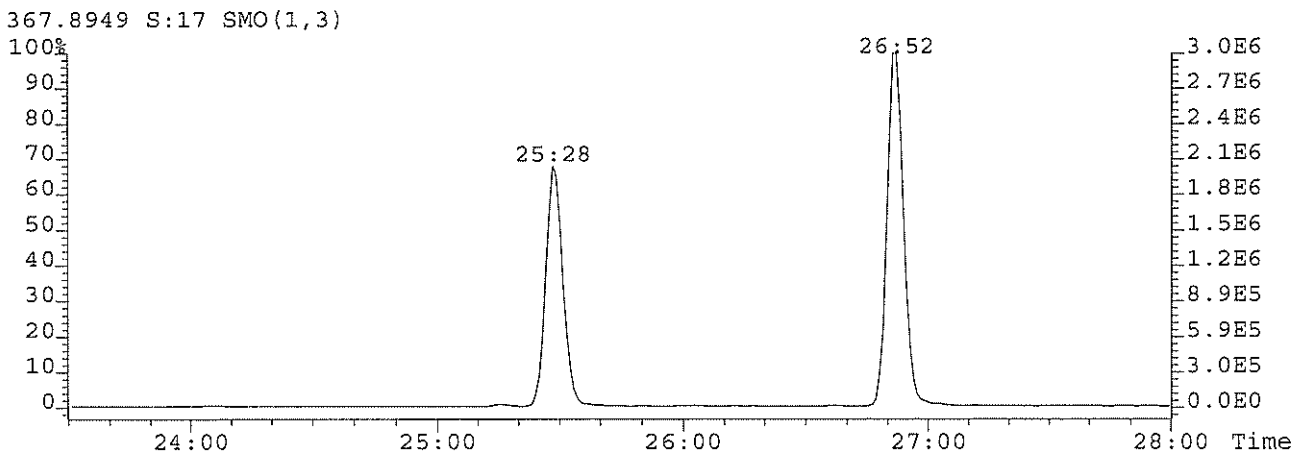
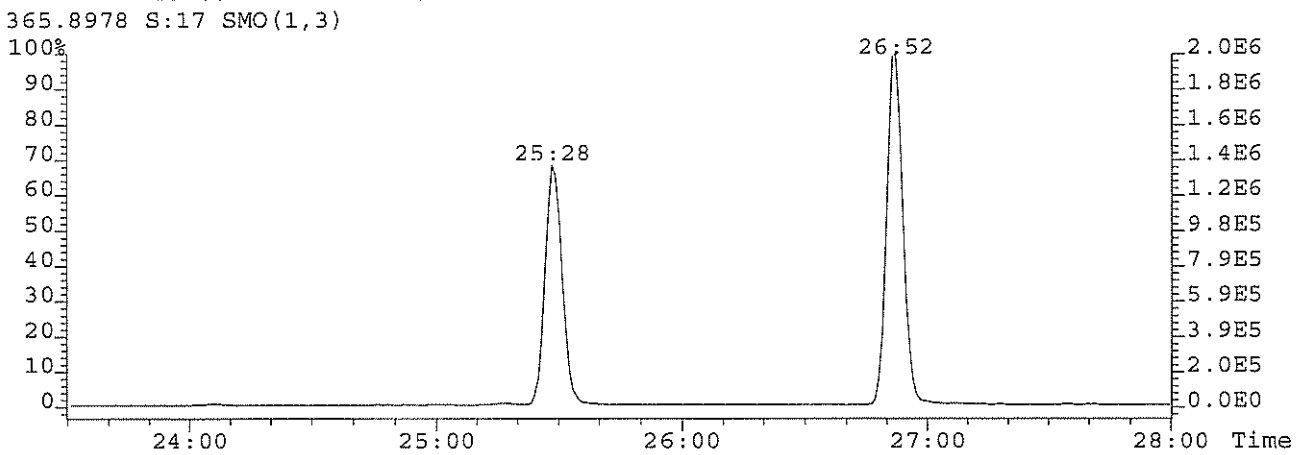
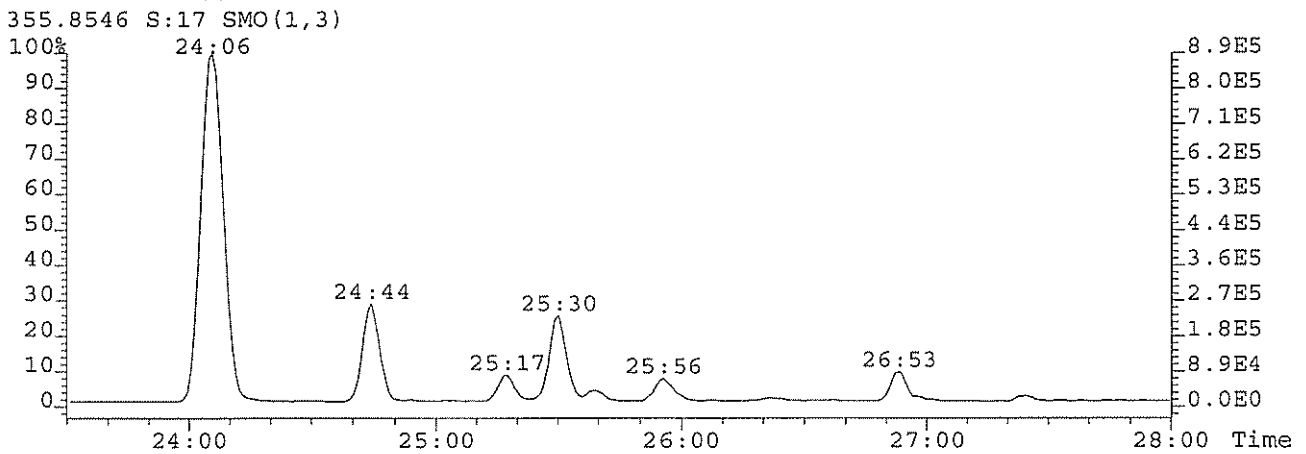
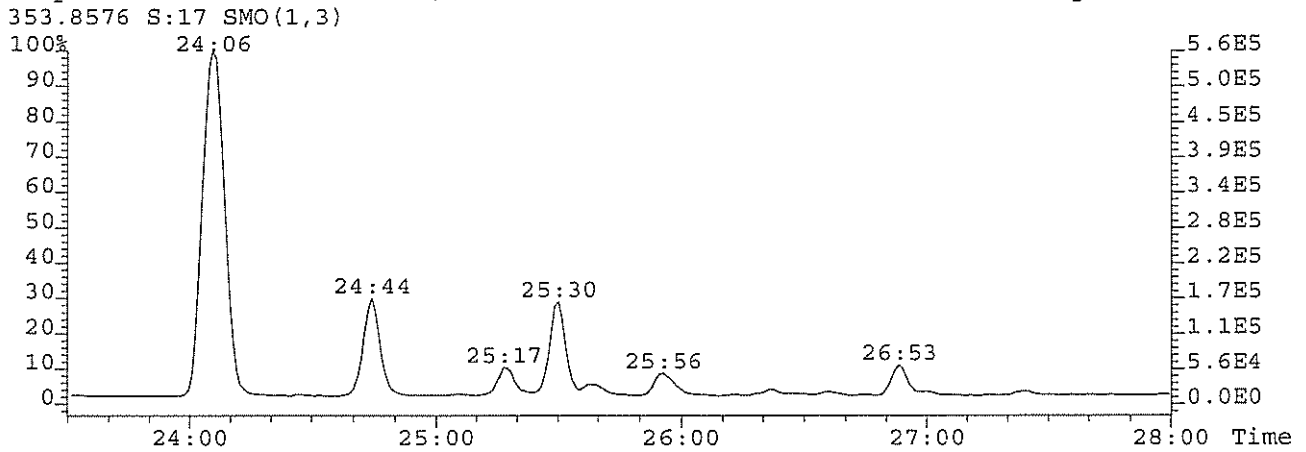


353.8970 S:17 SMO(1,3)



PCDFsクロマトグラム (3)  
(PeCDFs)

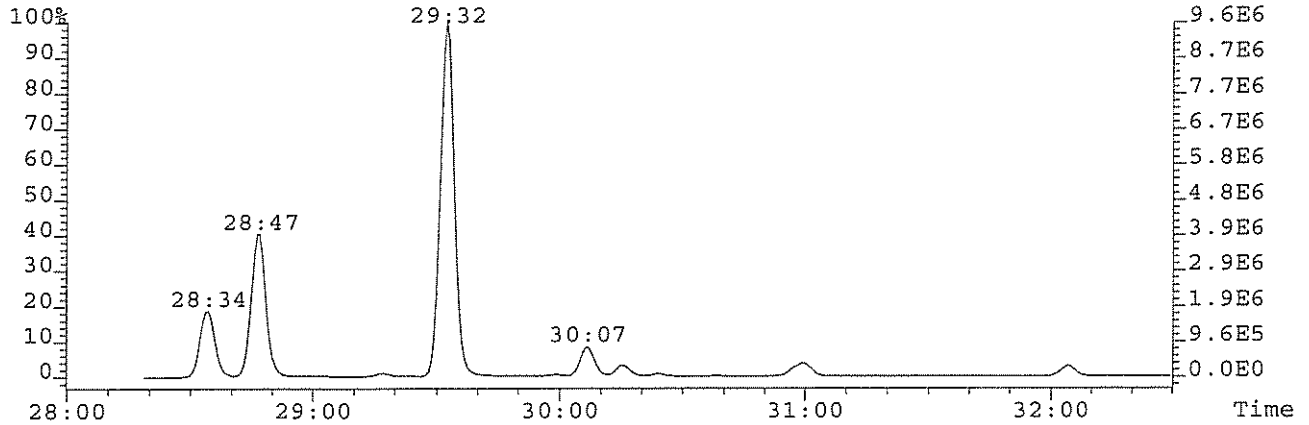
File:130712-2 #1-1577 Acq:13-JUL-2013 05:05:49 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:BPX-DXN(4-6DXN) Text:XE13 0960 Exp:BPX04



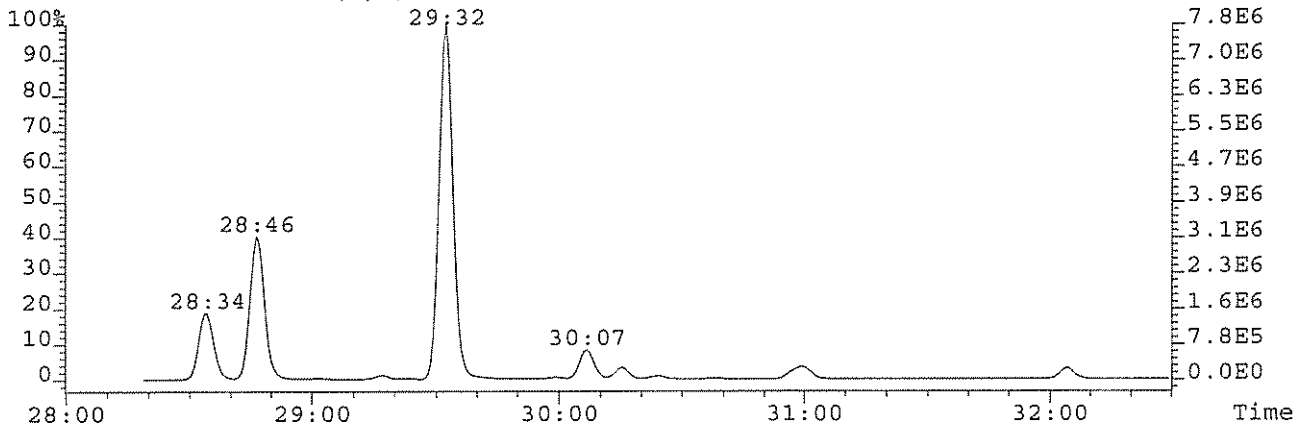
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130712-2 #1-1116 Acq:13-JUL-2013 05:05:49 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:BPX-DXN(4-6DXN) Text:XE13 0960 Exp:BPX04

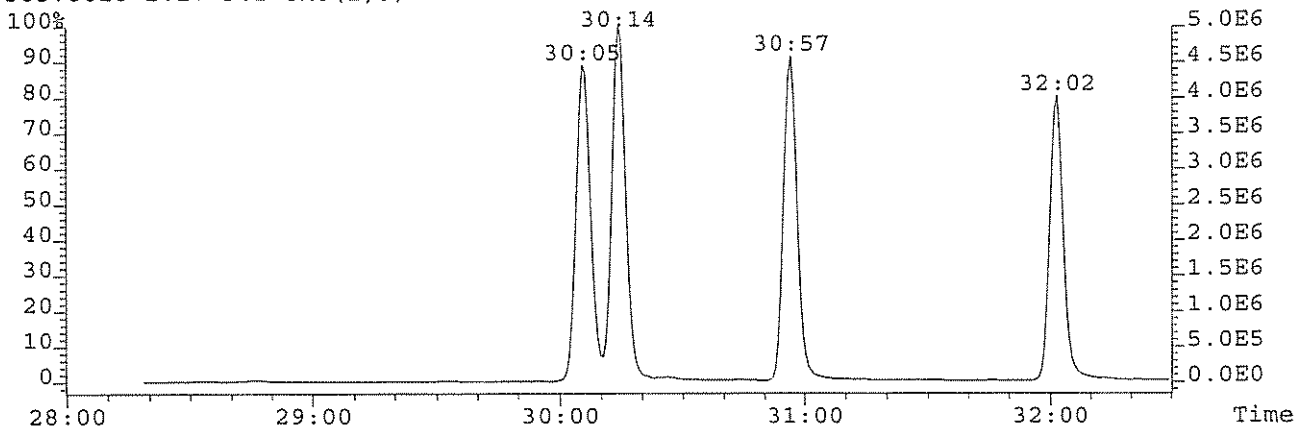
373.8207 S:17 F:2 SMO(1,3)



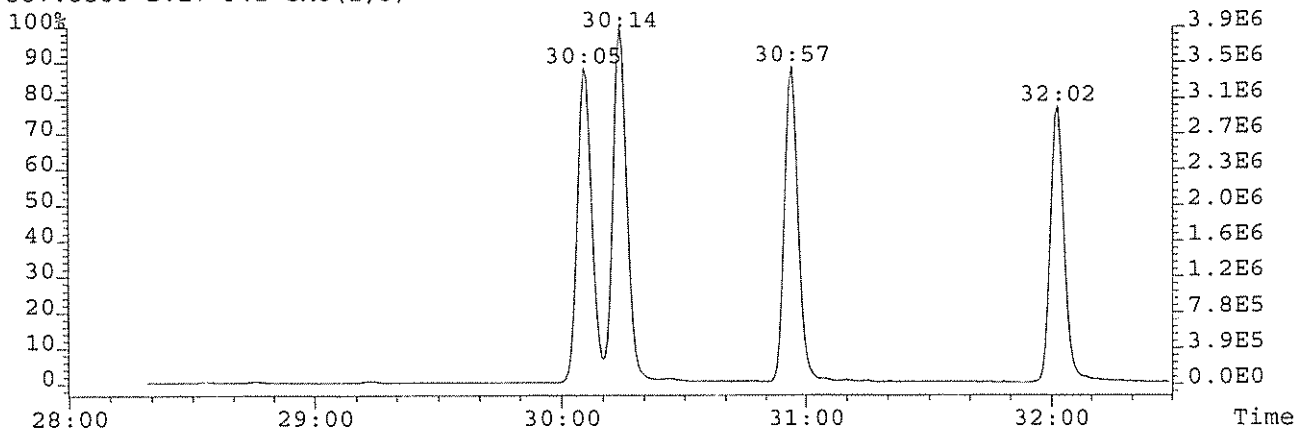
375.8178 S:17 F:2 SMO(1,3)



385.8610 S:17 F:2 SMO(1,3)



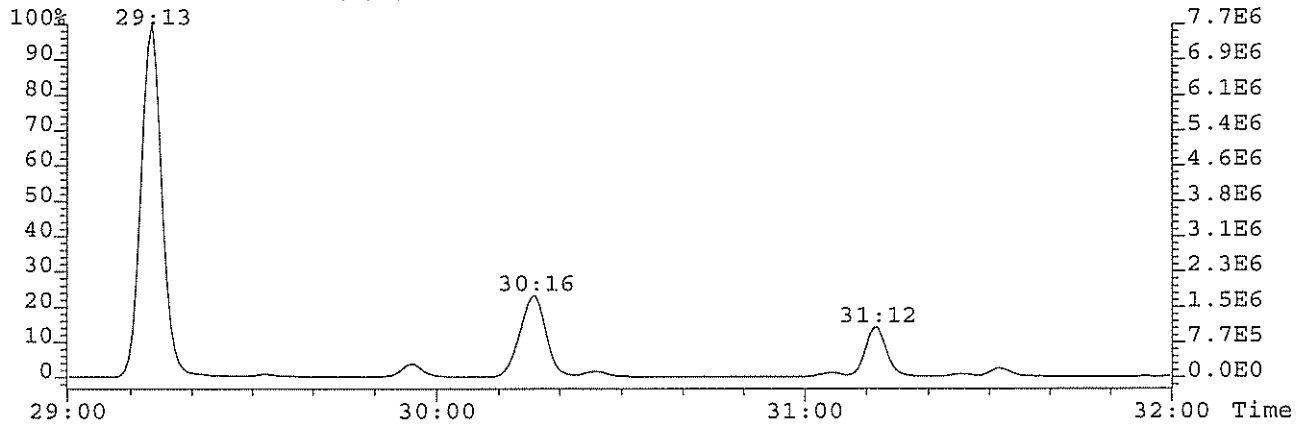
387.8580 S:17 F:2 SMO(1,3)



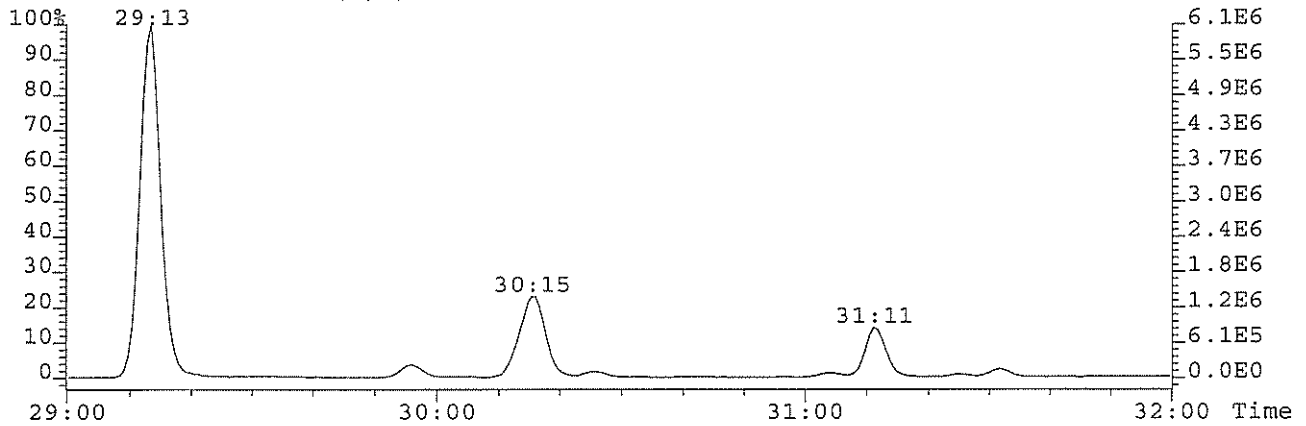
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1116 Acq:13-JUL-2013 05:05:49 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:BPX-DXN(4-6DXN) Text:XE13 0960 Exp:BPX04

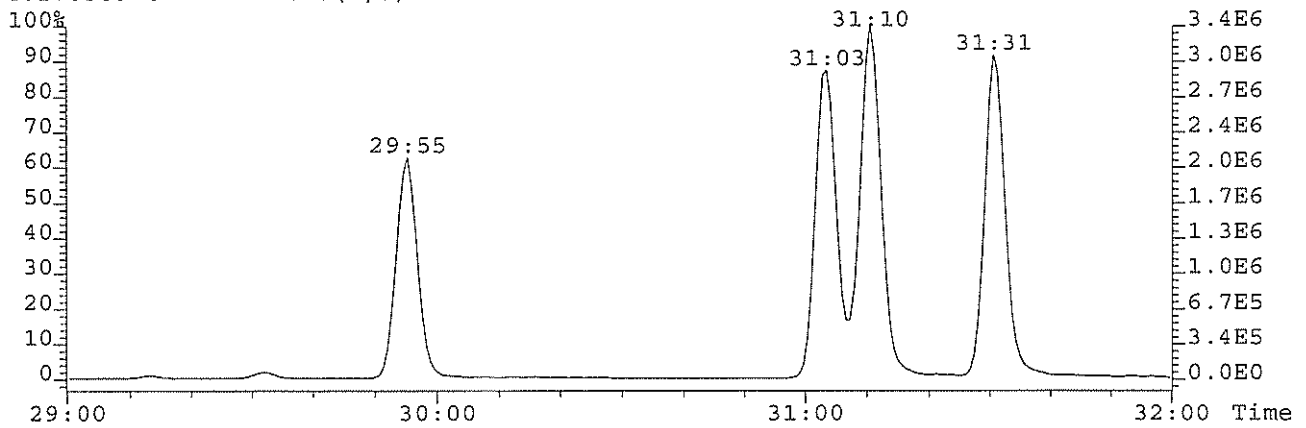
389.8156 S:17 F:2 SMO(1,3)



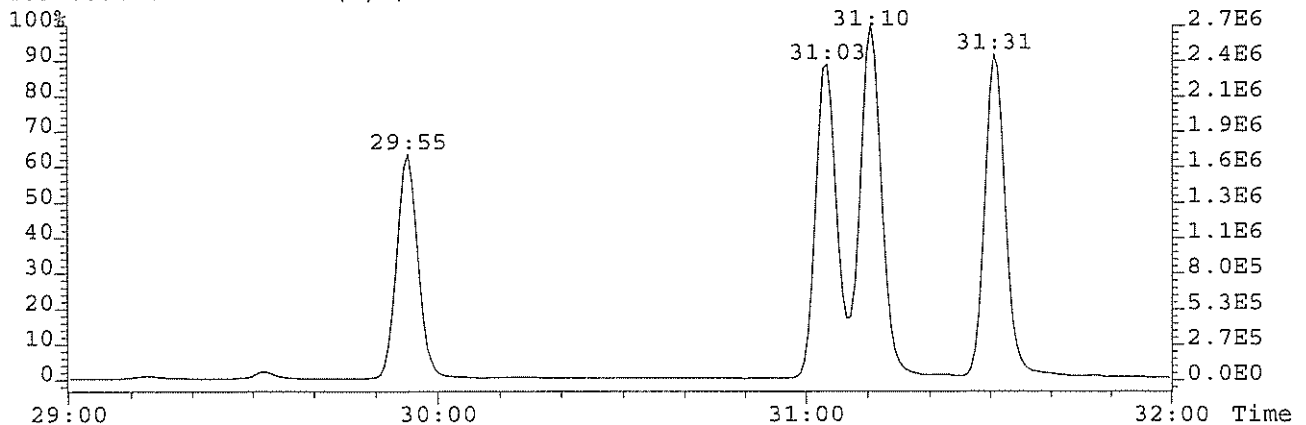
391.8127 S:17 F:2 SMO(1,3)



401.8559 S:17 F:2 SMO(1,3)



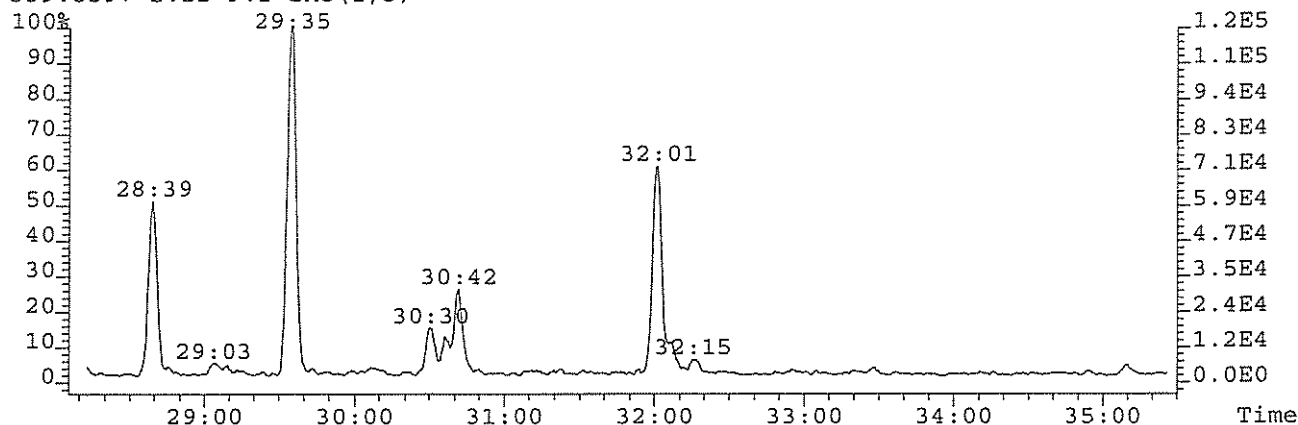
403.8530 S:17 F:2 SMO(1,3)



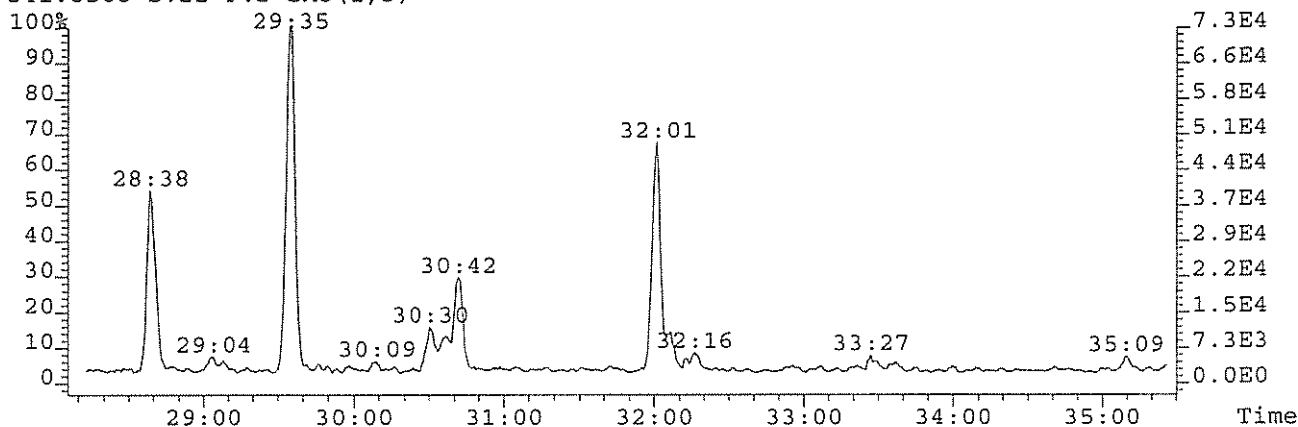
PCDDsクロマトグラム (6)  
(HxCDDs)

File:130711-2 #1-648 Acq:12-JUL-2013 12:11:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0960 3 Exp:RH-PD22

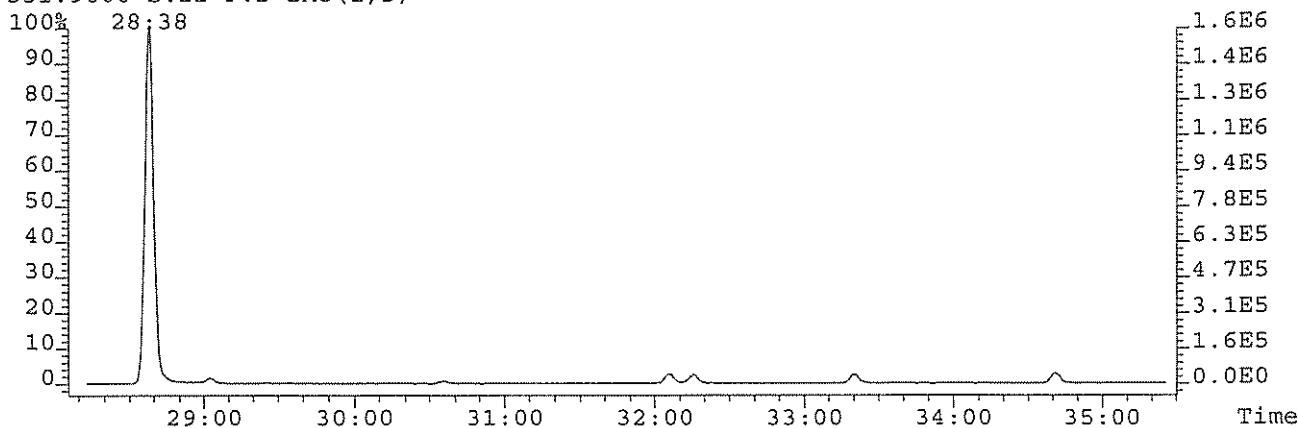
339.8597 S:22 F:2 SMO(1,3)



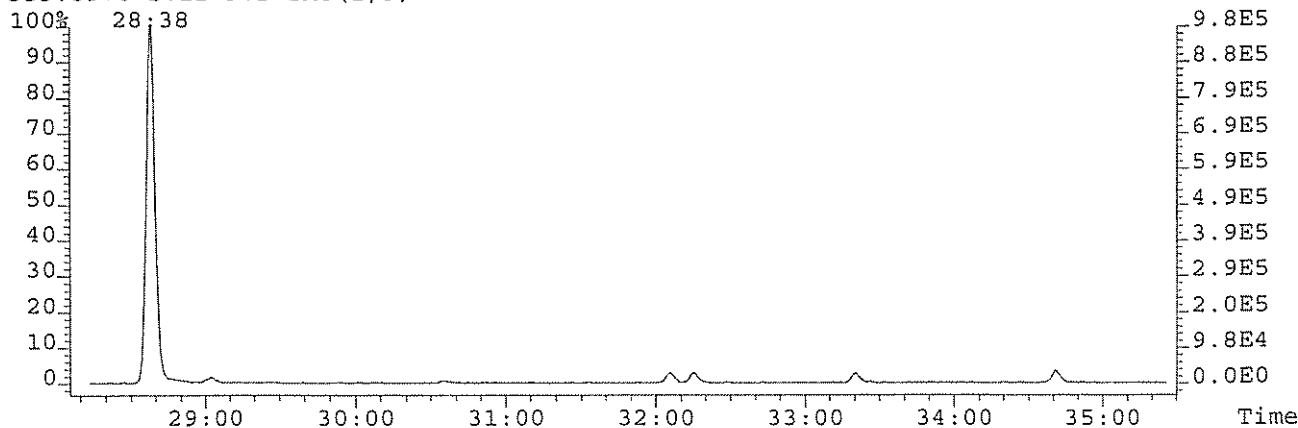
341.8568 S:22 F:2 SMO(1,3)



351.9000 S:22 F:2 SMO(1,3)

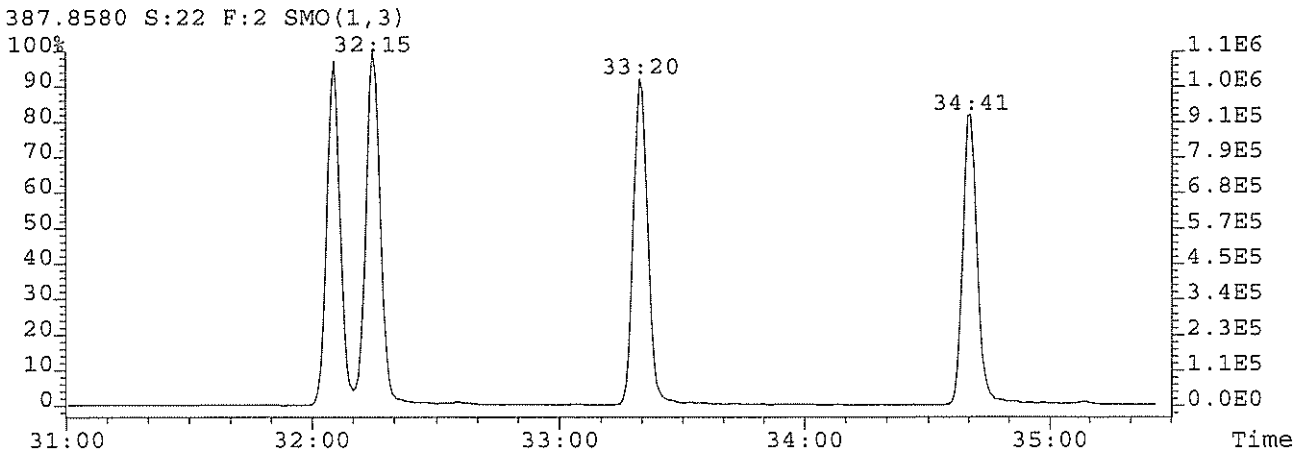
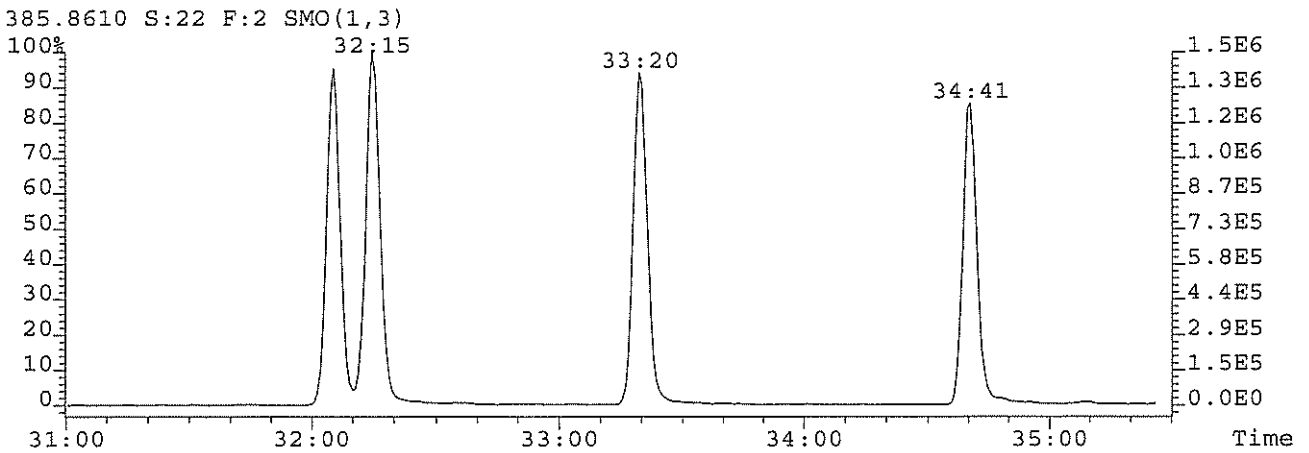
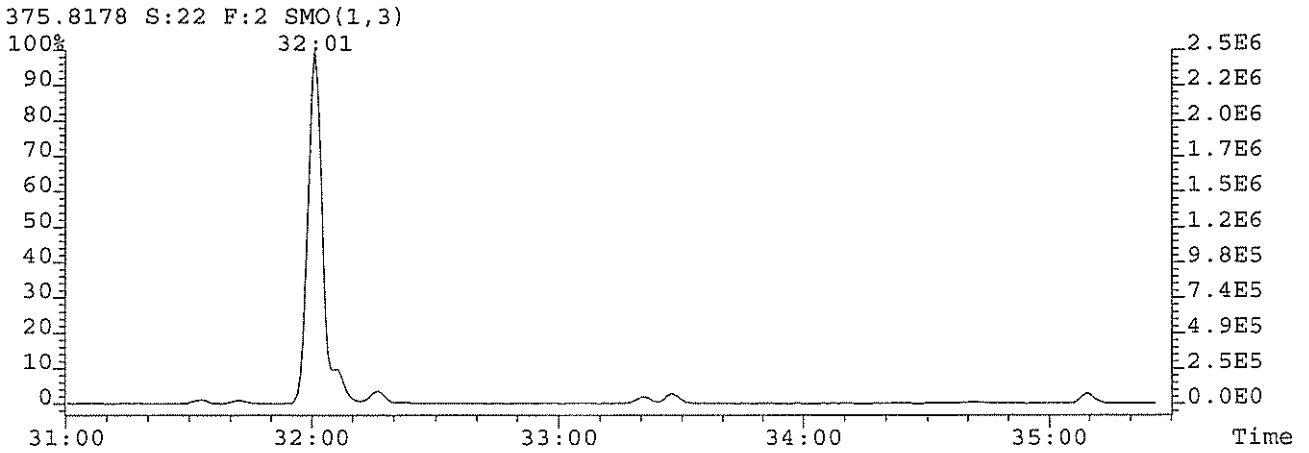
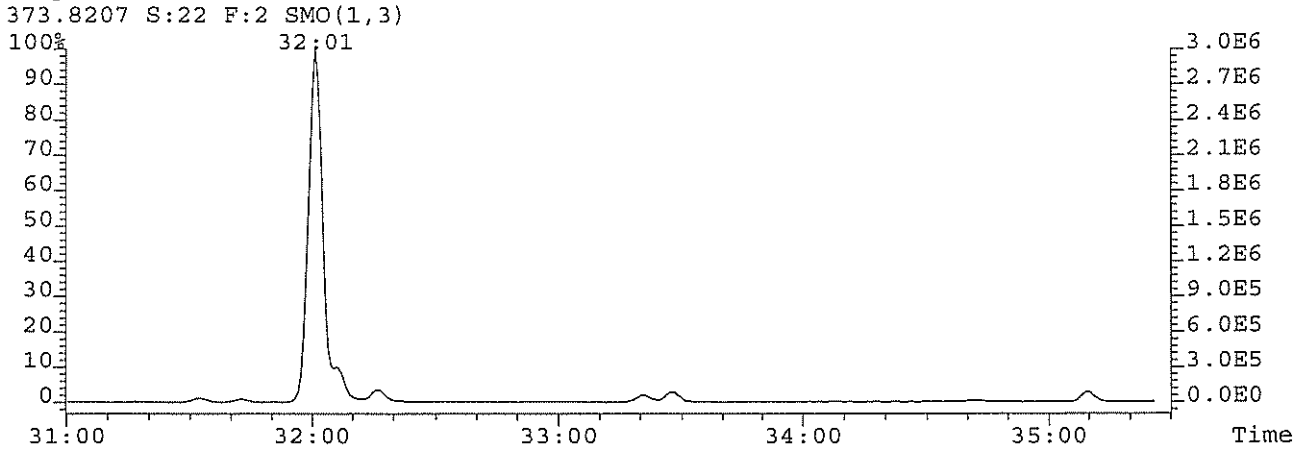


353.8970 S:22 F:2 SMO(1,3)



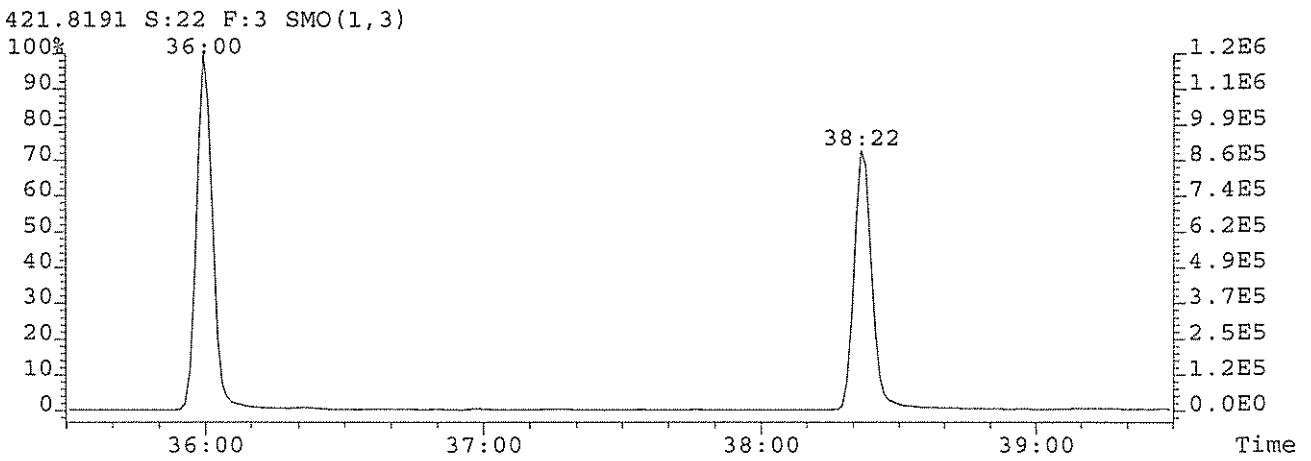
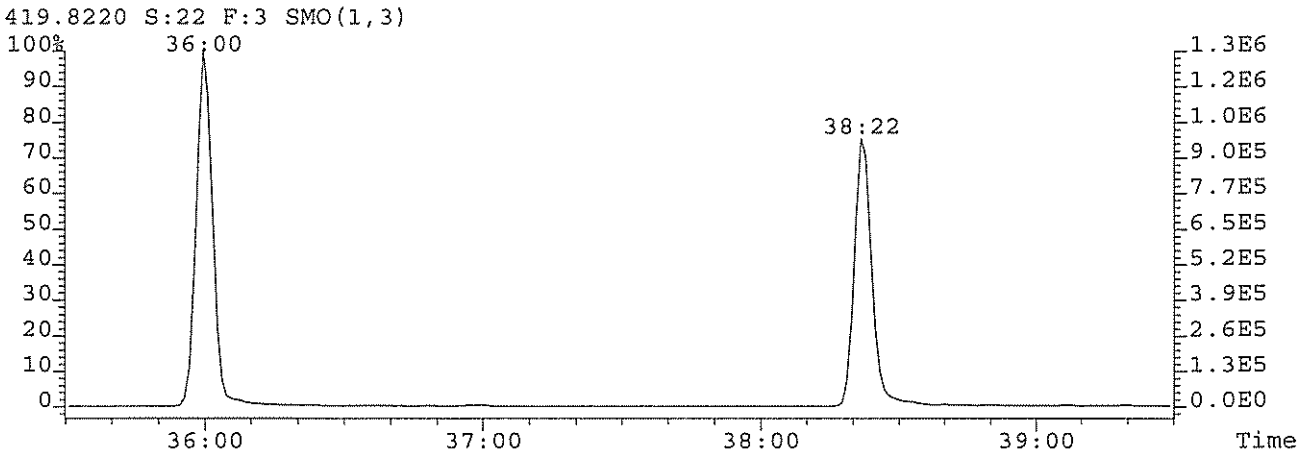
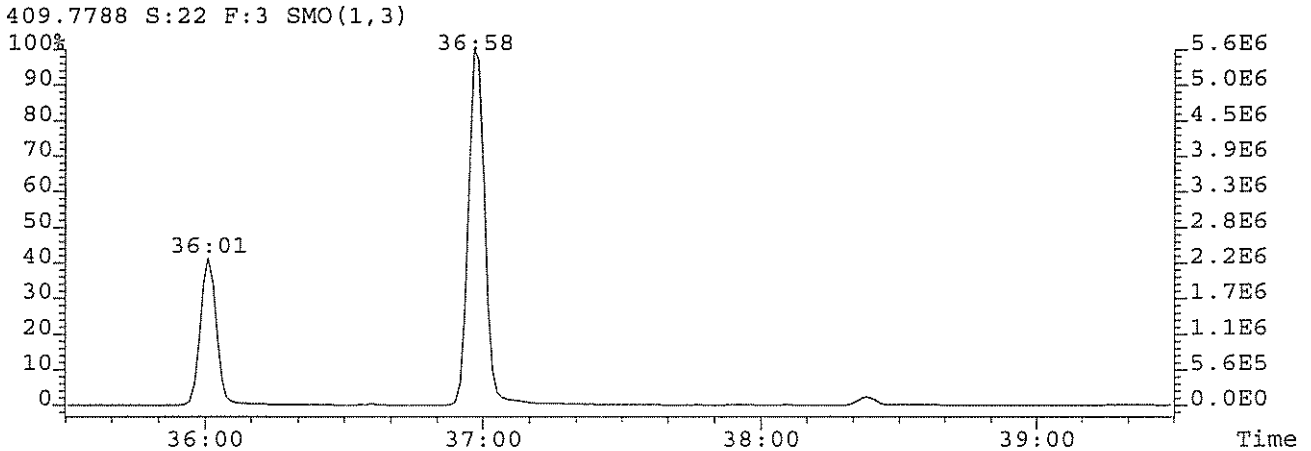
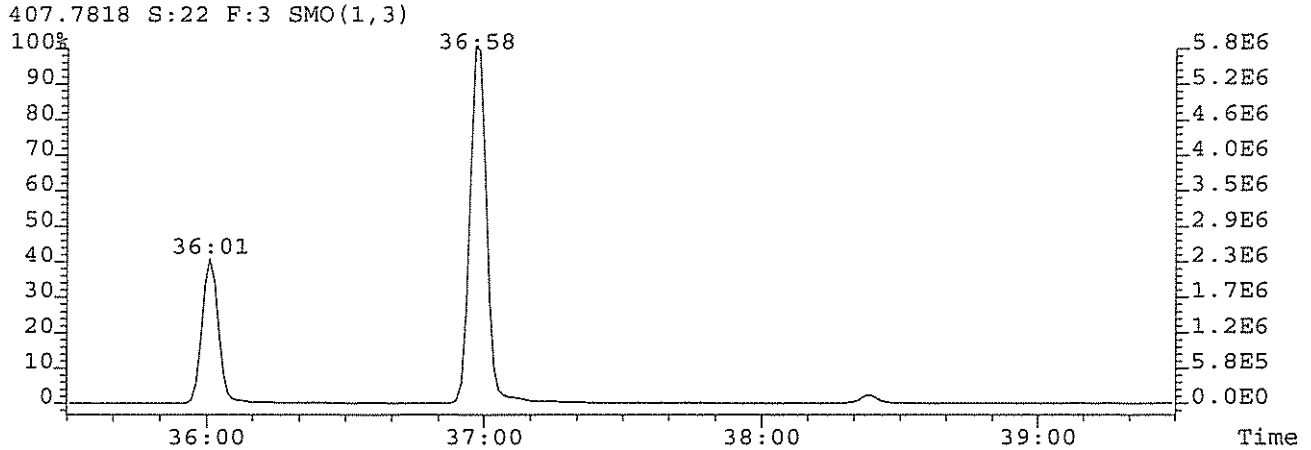
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130711-2 #1-648 Acq:12-JUL-2013 12:11:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0960 3 Exp:RH-PD22



HxCDFsクロマトグラム (8)  
(123789-HxCDF)

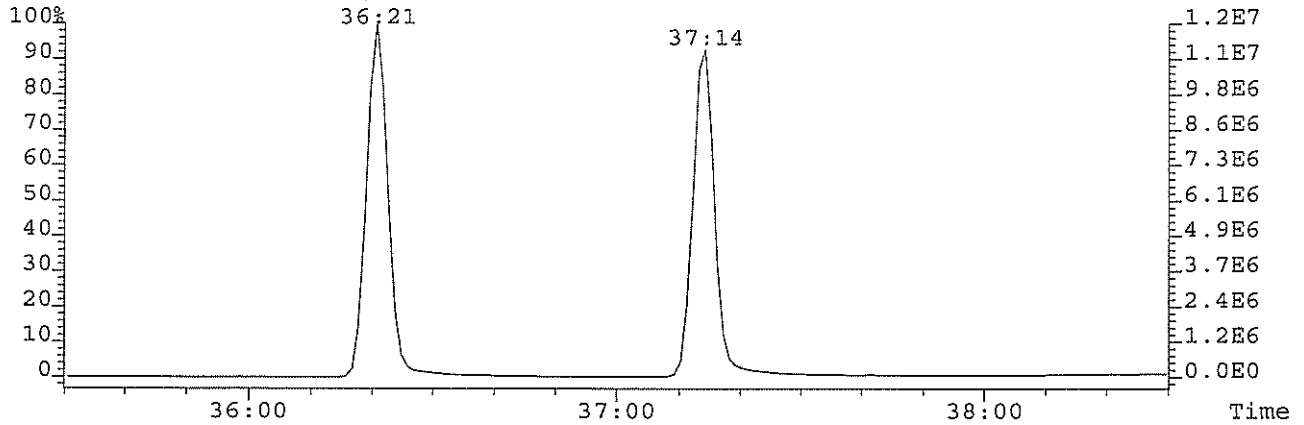
File:130711-2 #1-562 Acq:12-JUL-2013 12:11:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0960 3 Exp:RH-PD22



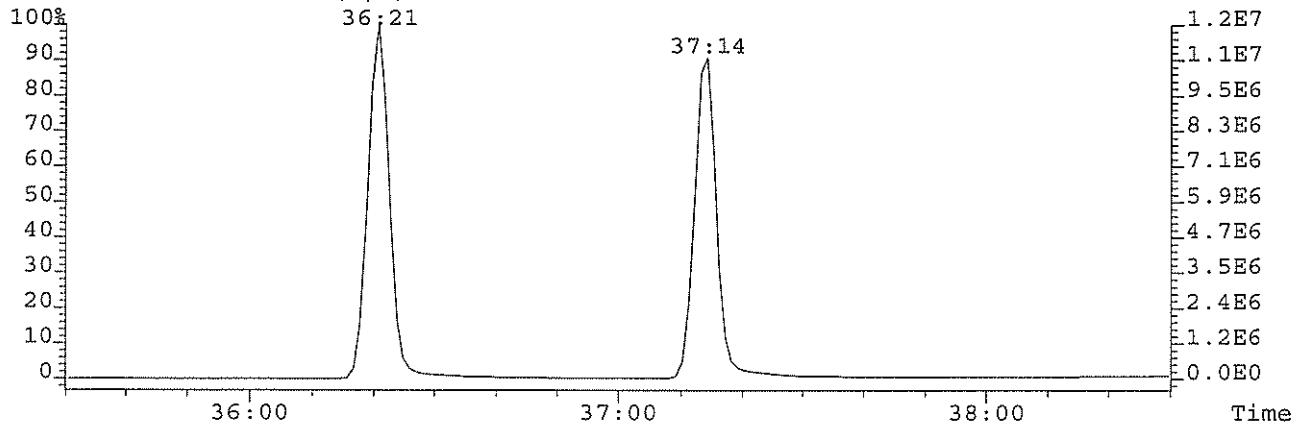
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130711-2 #1-562 Acq:12-JUL-2013 12:11:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0960 3 Exp:RH-PD22

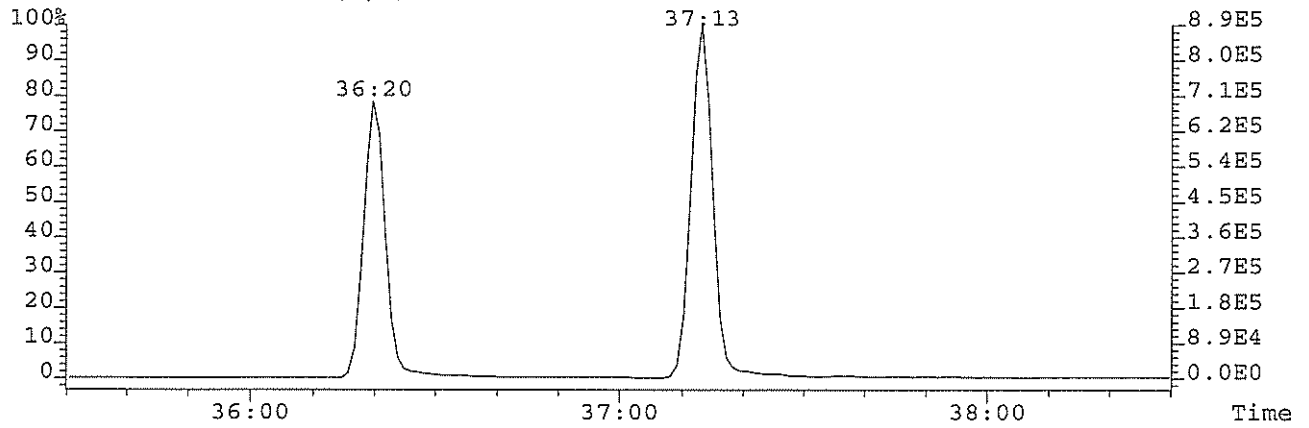
423.7767 S:22 F:3 SMO(1,3)



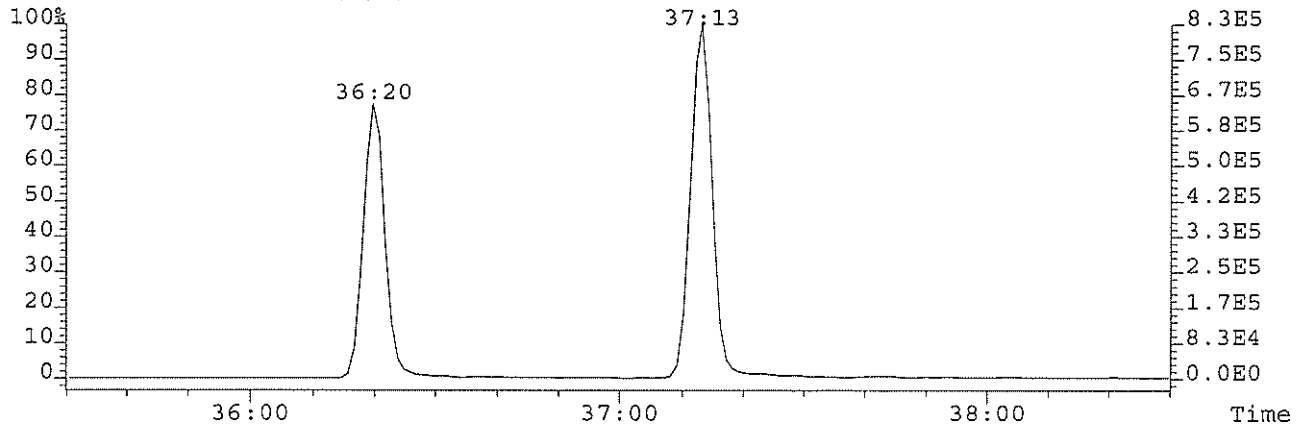
425.7737 S:22 F:3 SMO(1,3)



435.8169 S:22 F:3 SMO(1,3)



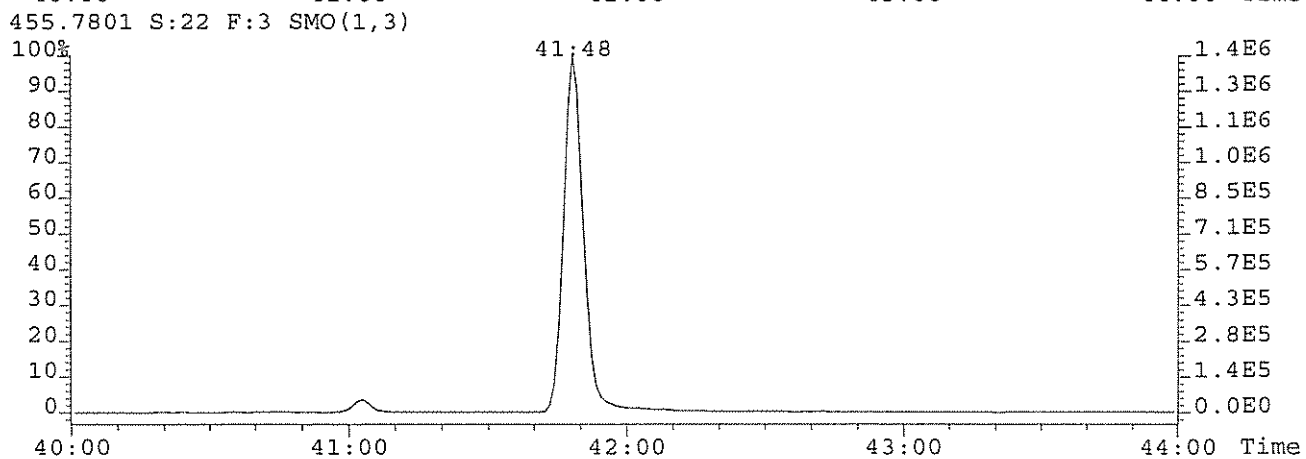
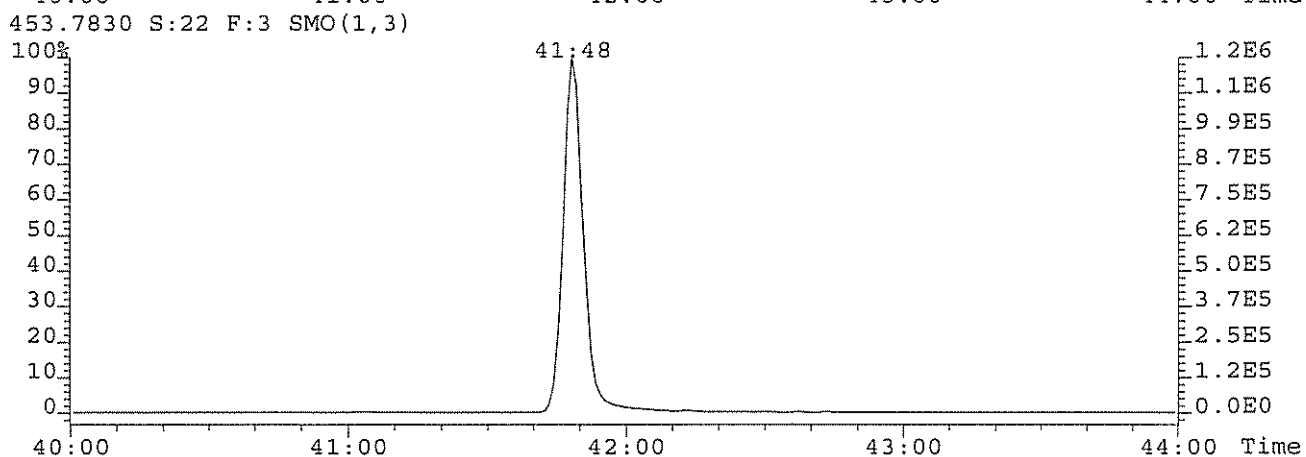
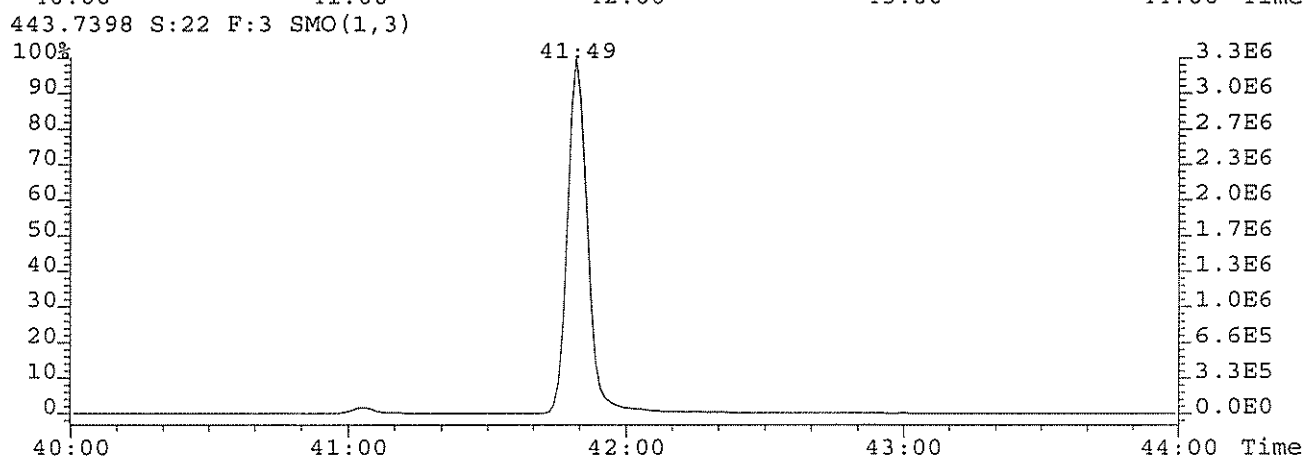
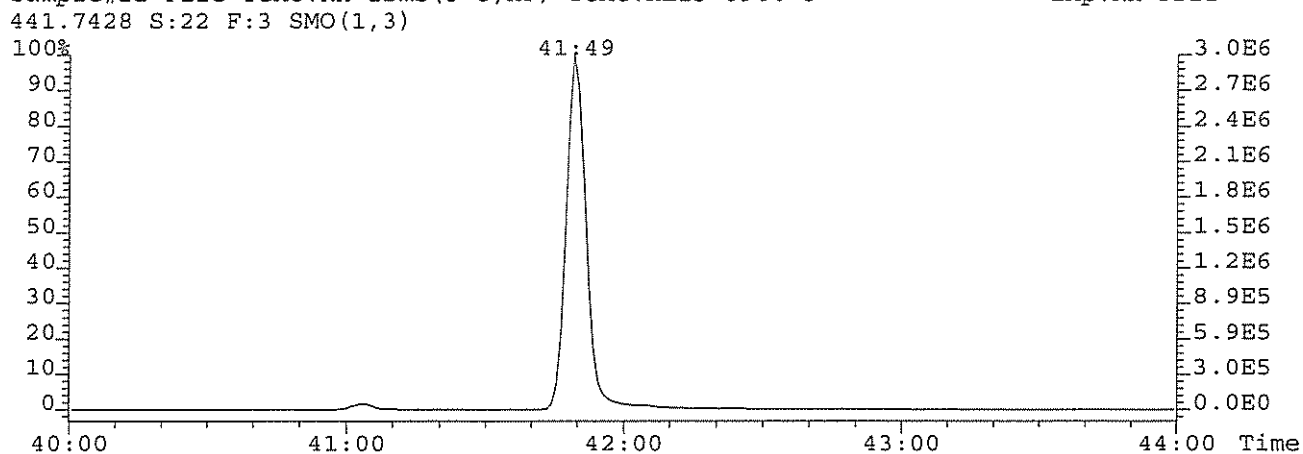
437.8140 S:22 F:3 SMO(1,3)



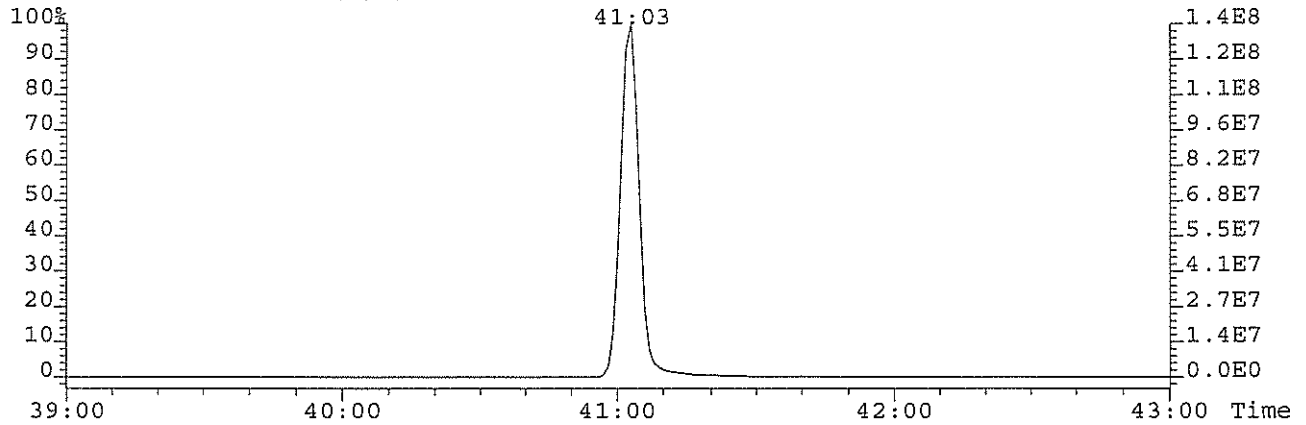
PCDDsクロマトグラム (10)  
(HpCDDs)



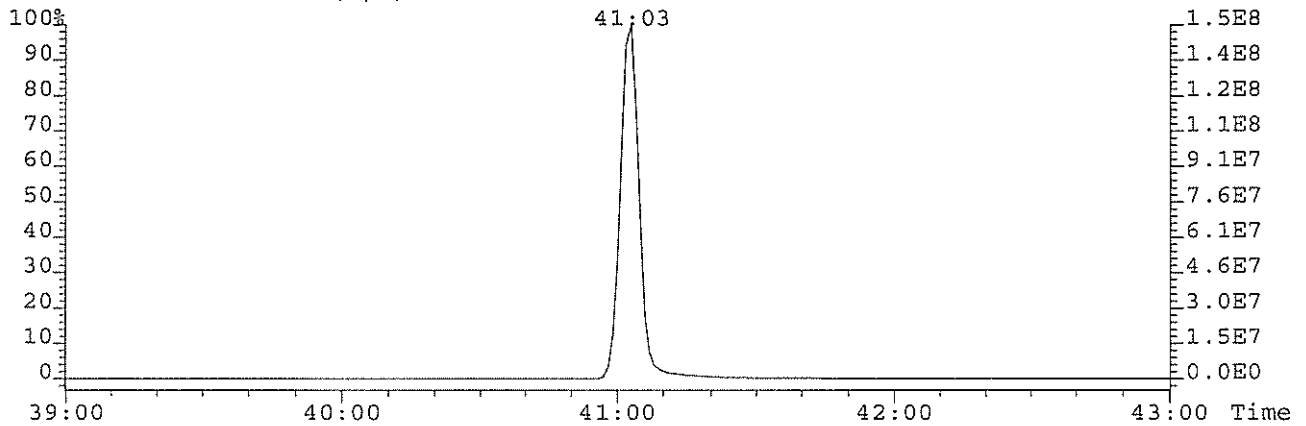
File:130711-2 #1-562 Acq:12-JUL-2013 12:11:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0960 3 Exp:RH-PD22



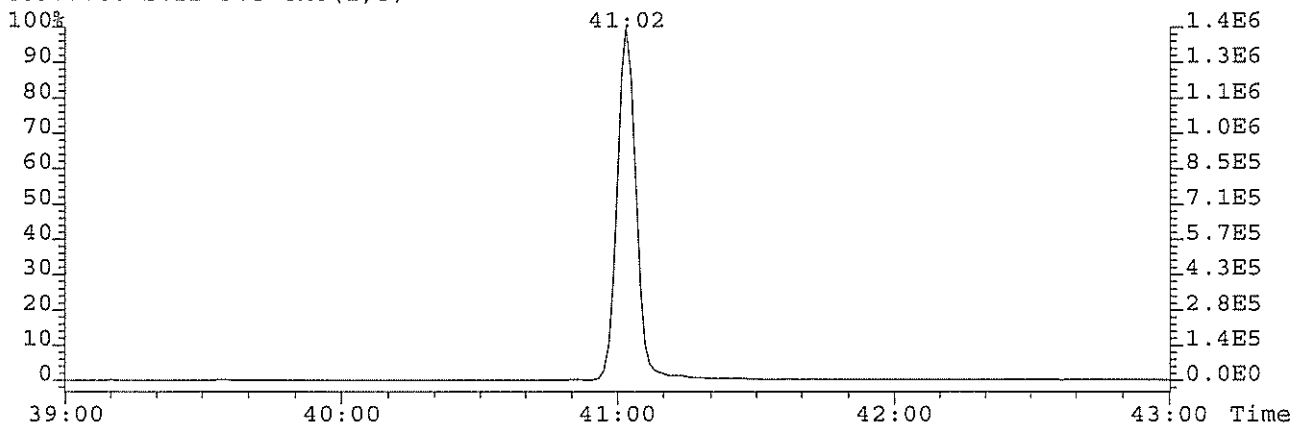
File:130711-2 #1-562 Acq:12-JUL-2013 12:11:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0960 3 Exp:RH-PD22  
457.7377 S:22 F:3 SMO(1,3)



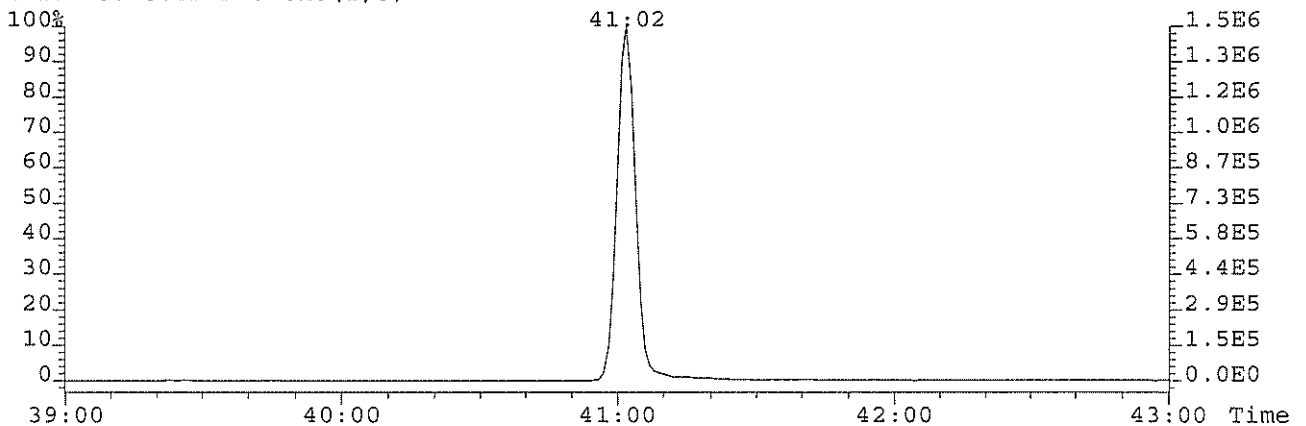
459.7348 S:22 F:3 SMO(1,3)



469.7780 S:22 F:3 SMO(1,3)



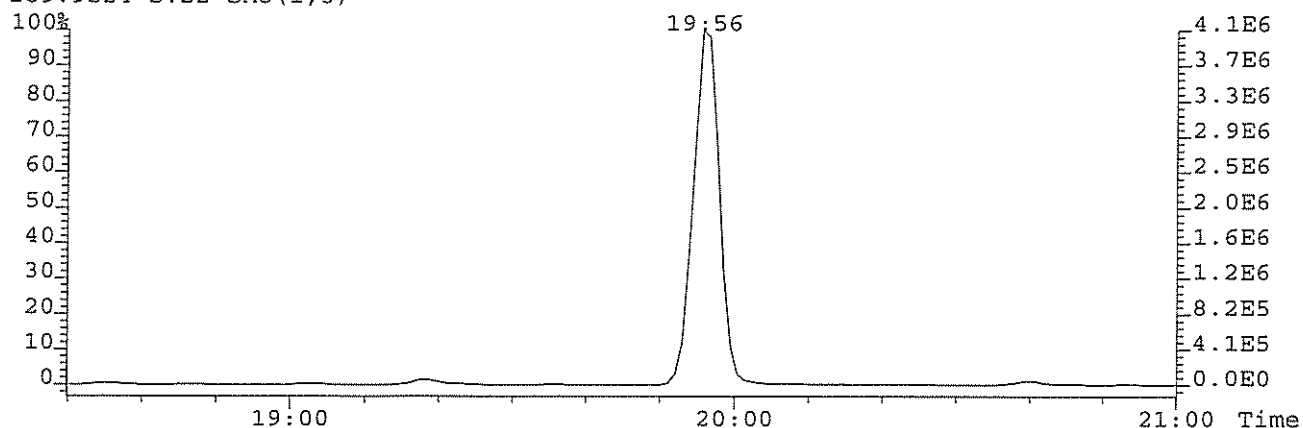
471.7750 S:22 F:3 SMO(1,3)



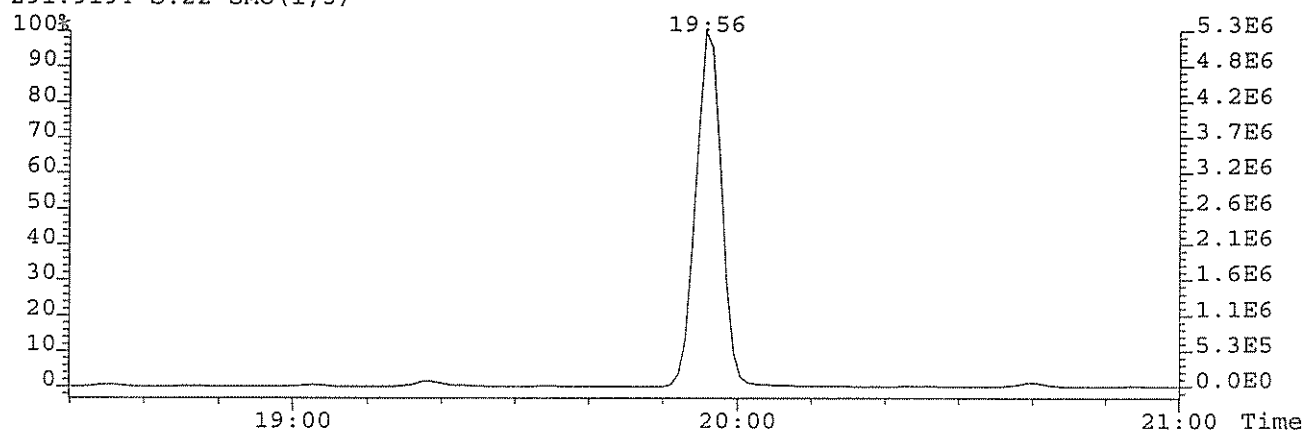
PCDDsクロマトグラム (12)  
(OCDD)

File:130711-2 #1-1430 Acq:12-JUL-2013 12:11:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0960 3 Exp:RH-PD22

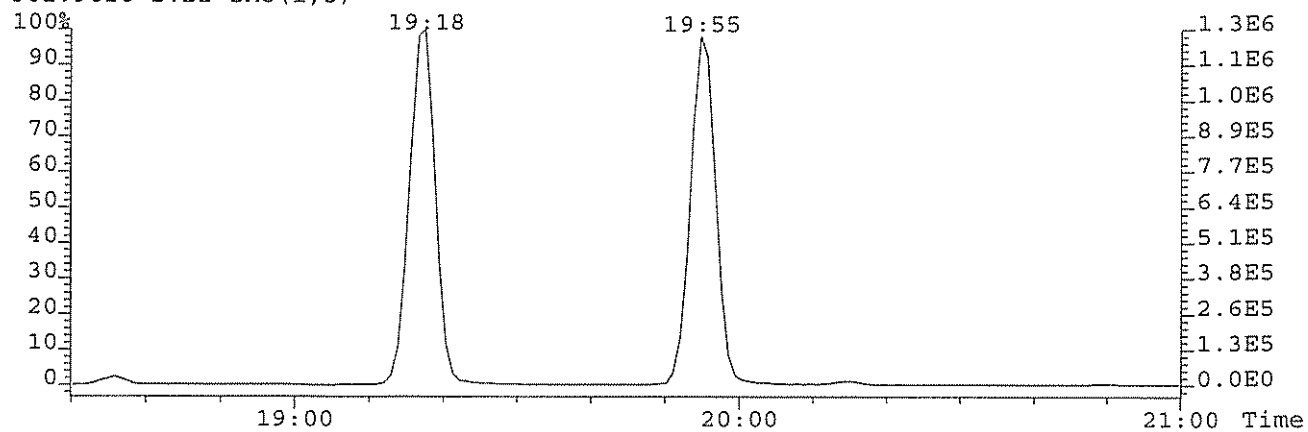
289.9224 S:22 SMO(1,3)



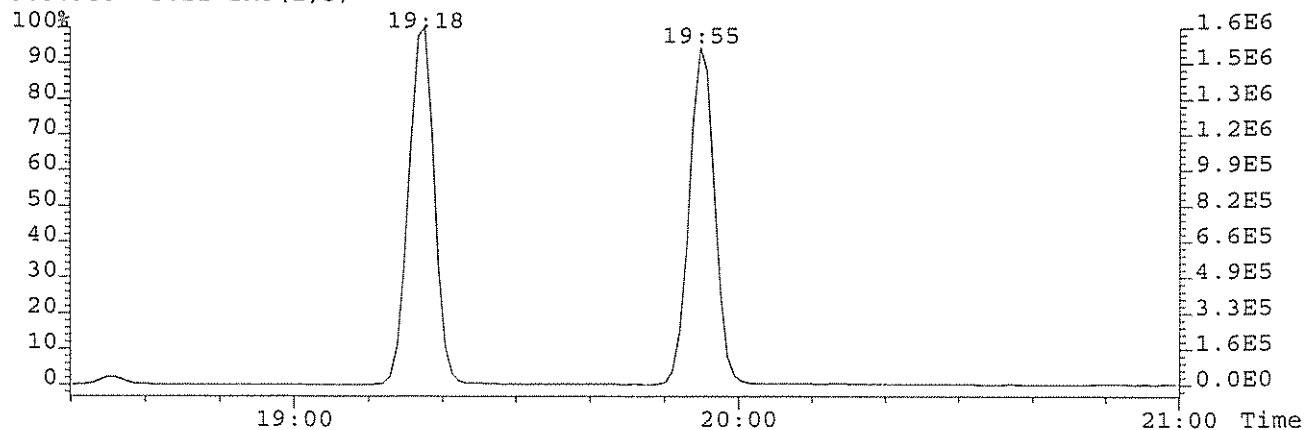
291.9194 S:22 SMO(1,3)



301.9626 S:22 SMO(1,3)

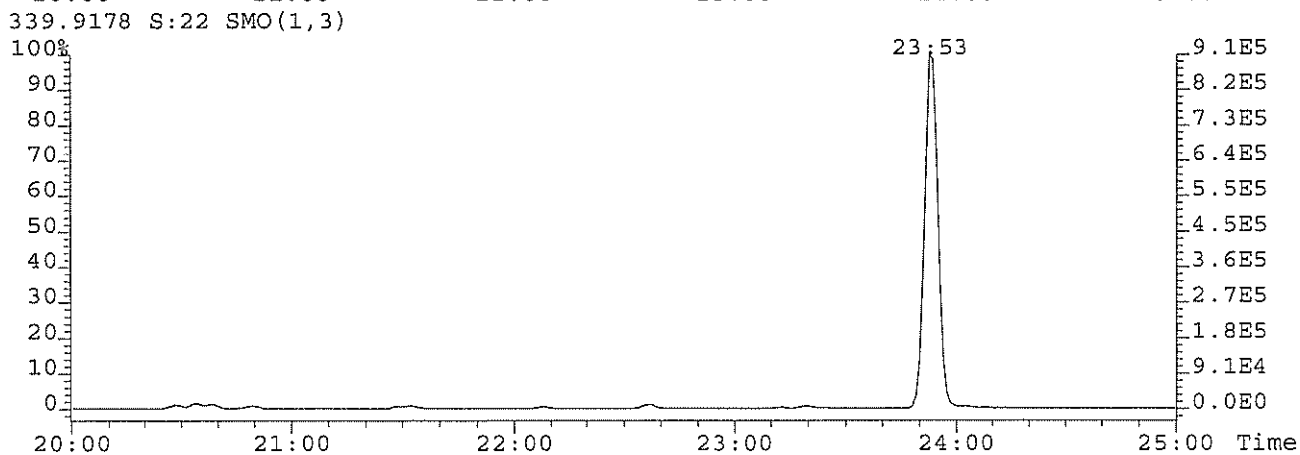
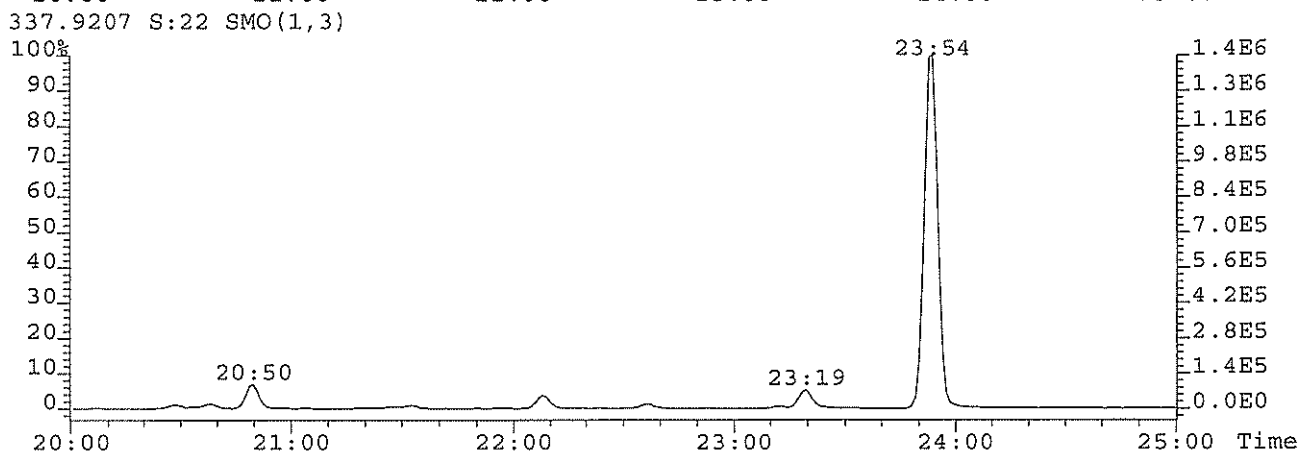
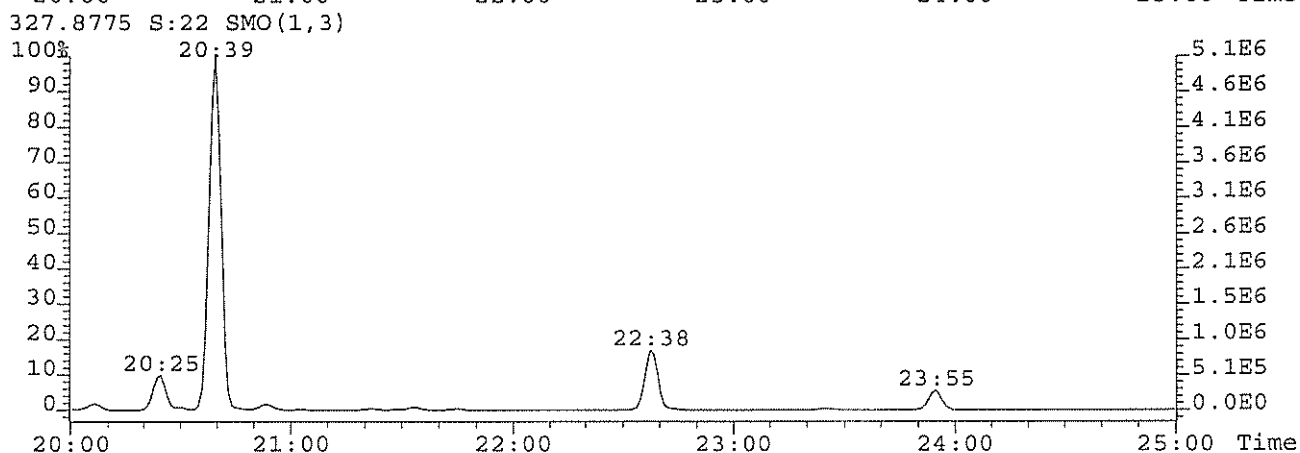
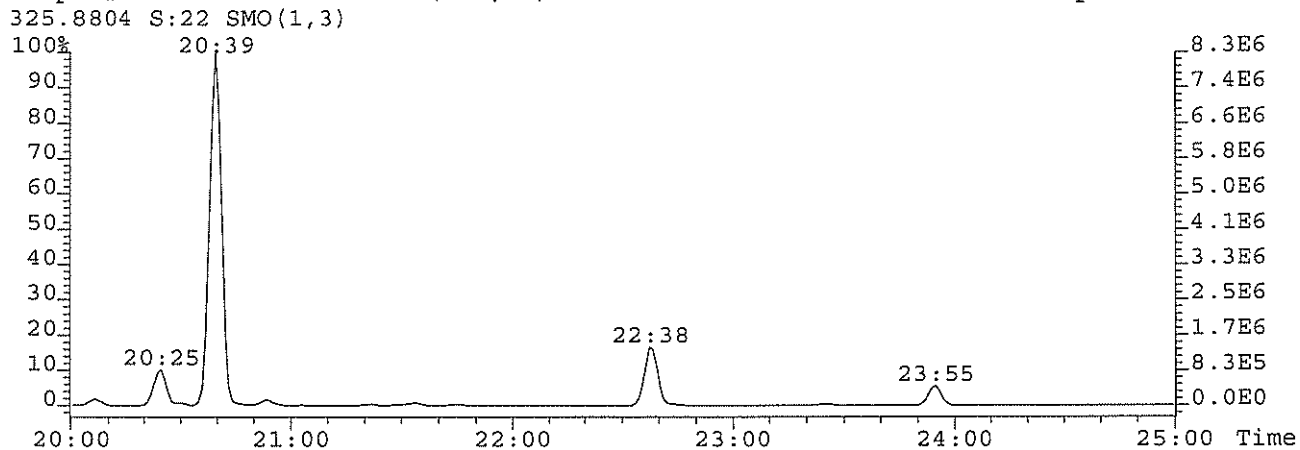


303.9597 S:22 SMO(1,3)



DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

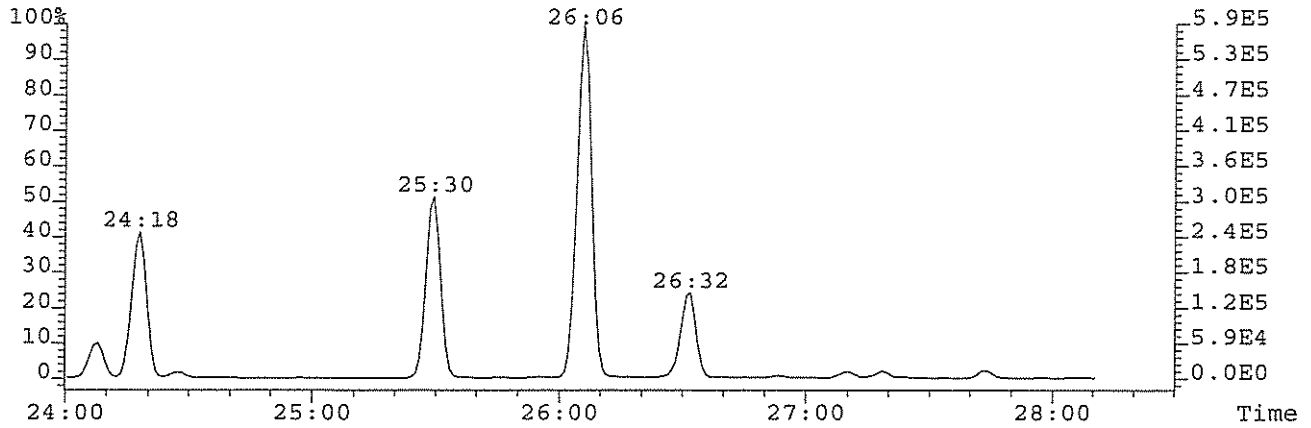
File:130711-2 #1-1430 Acq:12-JUL-2013 12:11:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0960 3 Exp:RH-PD22



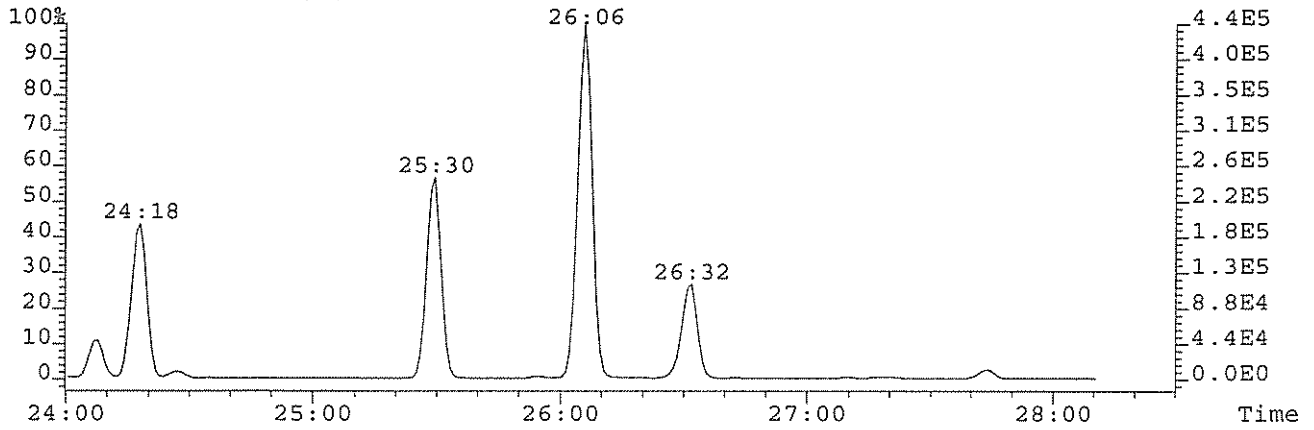
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130711-2 #1-1430 Acq:12-JUL-2013 12:11:13 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0960 3 Exp:RH-PD22

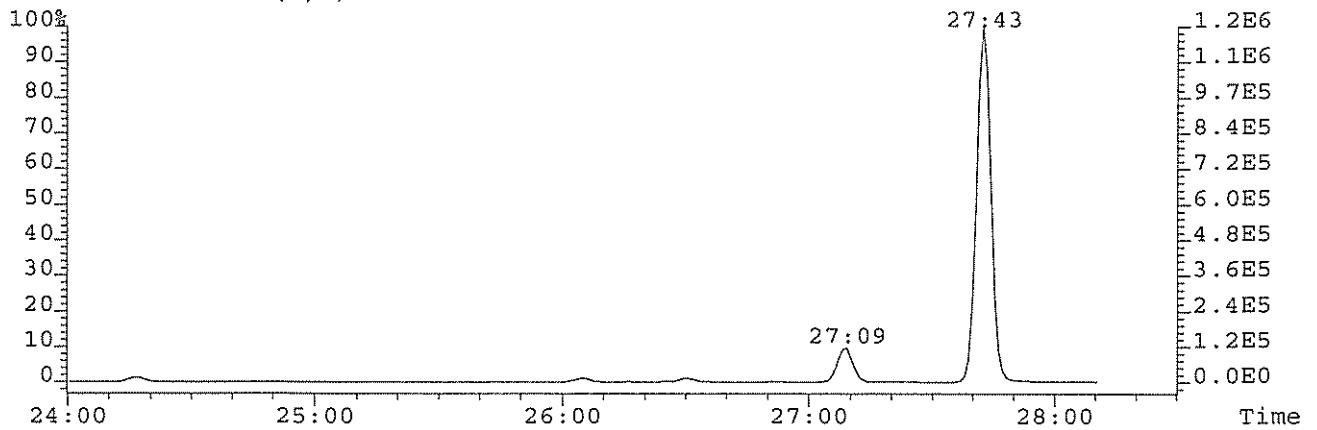
359.8415 S:22 SMO(1,3)



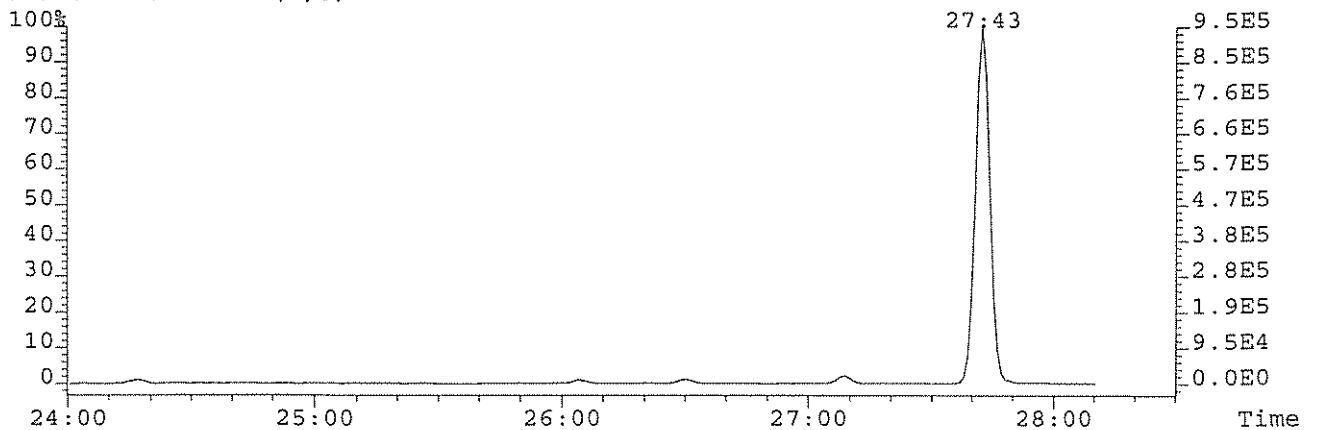
361.8385 S:22 SMO(1,3)



371.8817 S:22 SMO(1,3)

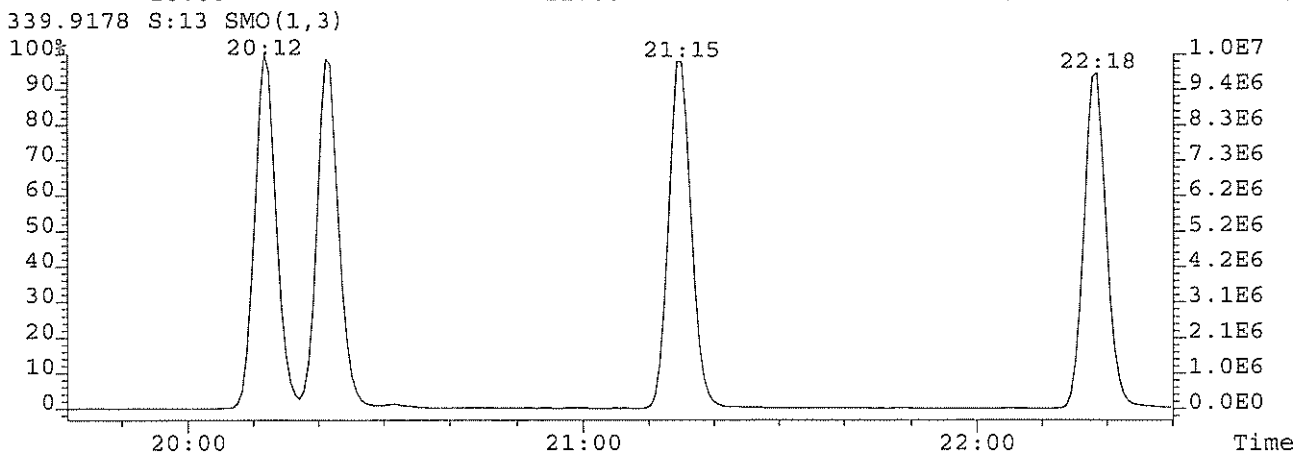
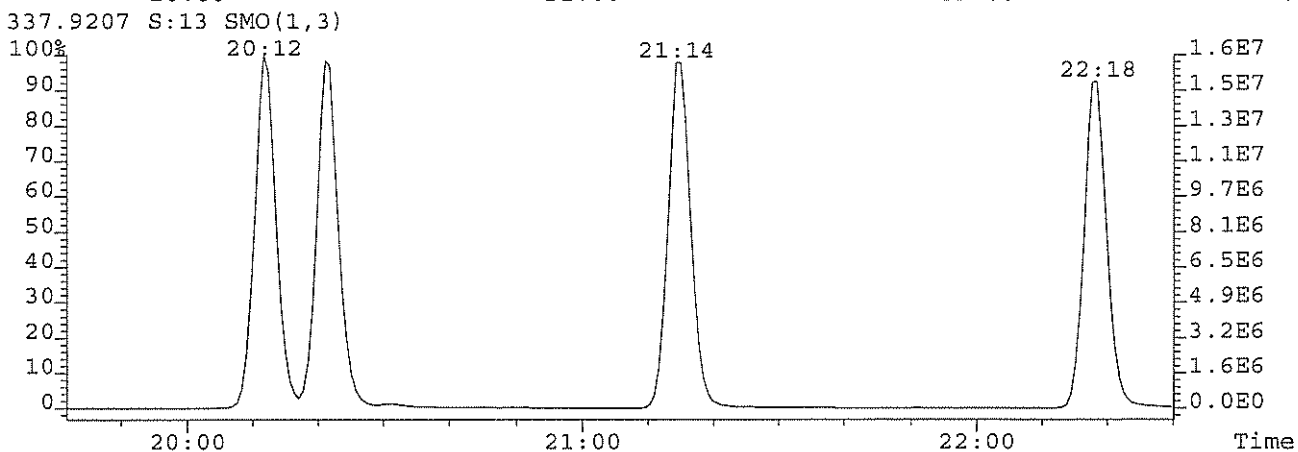
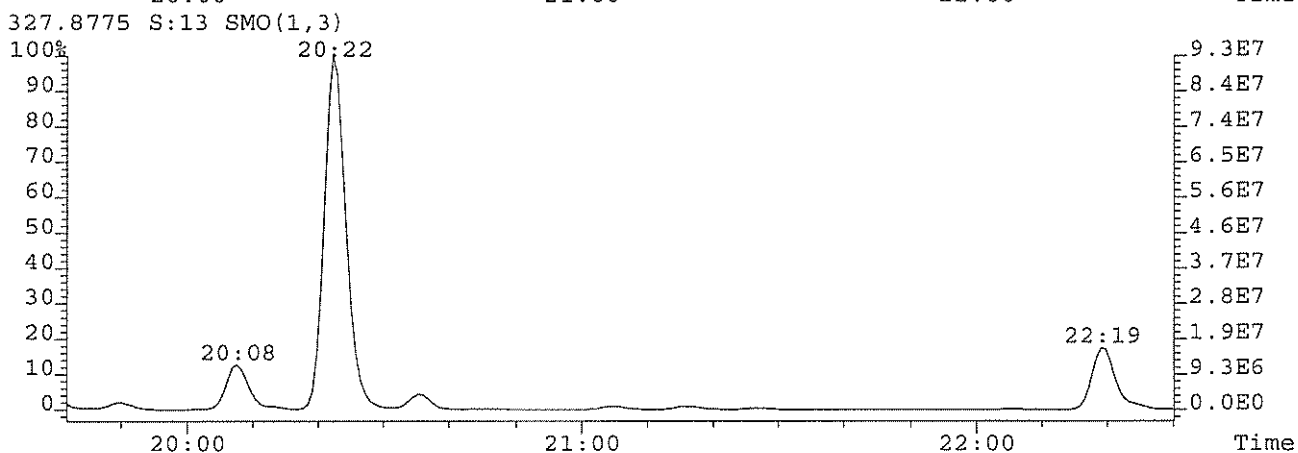
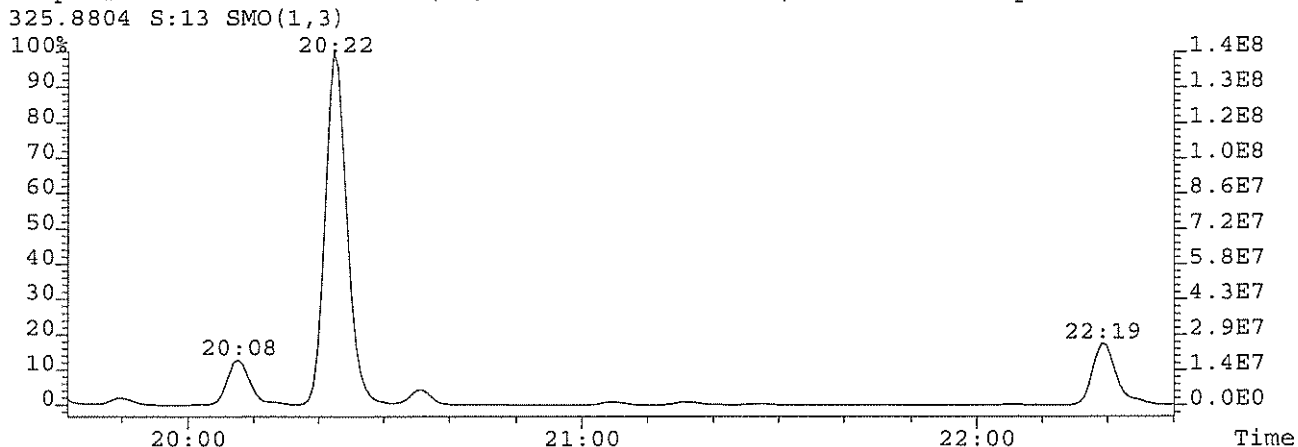


373.8788 S:22 SMO(1,3)



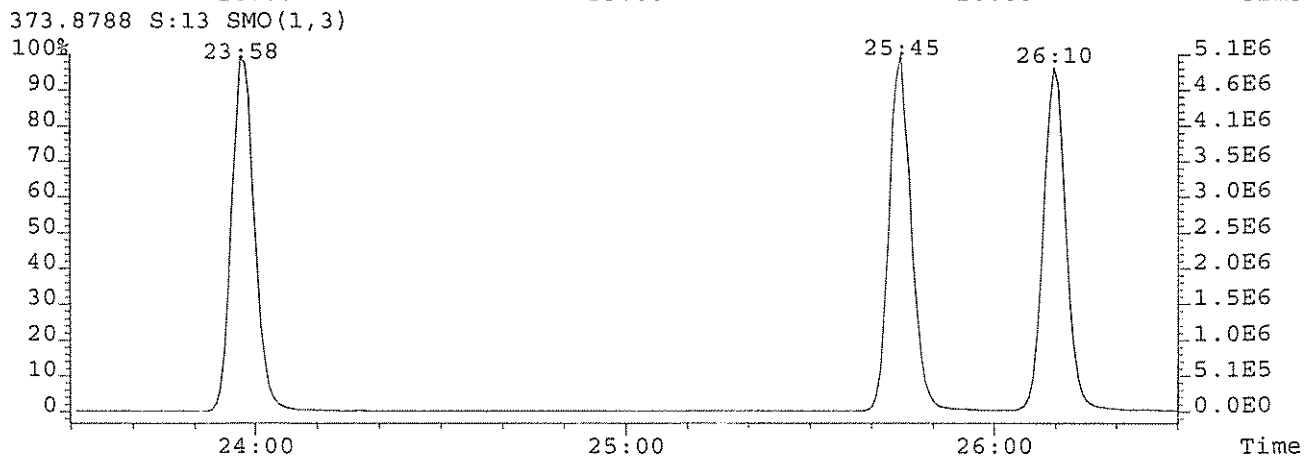
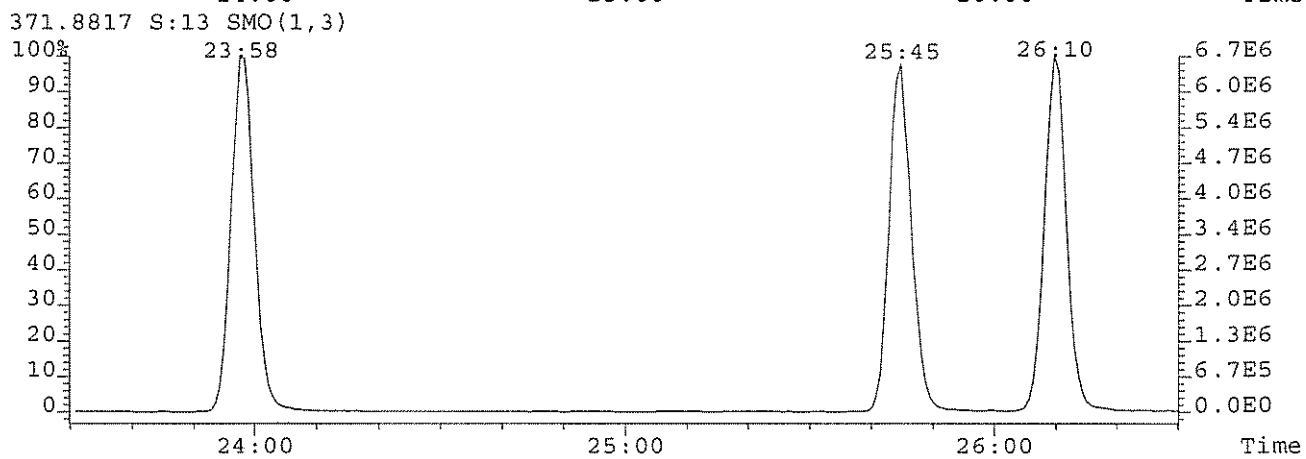
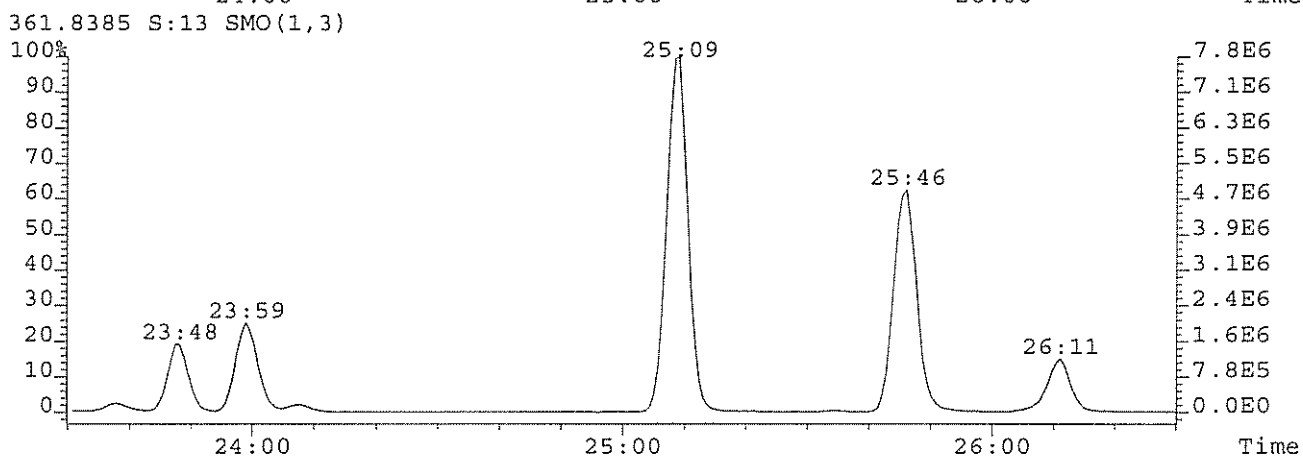
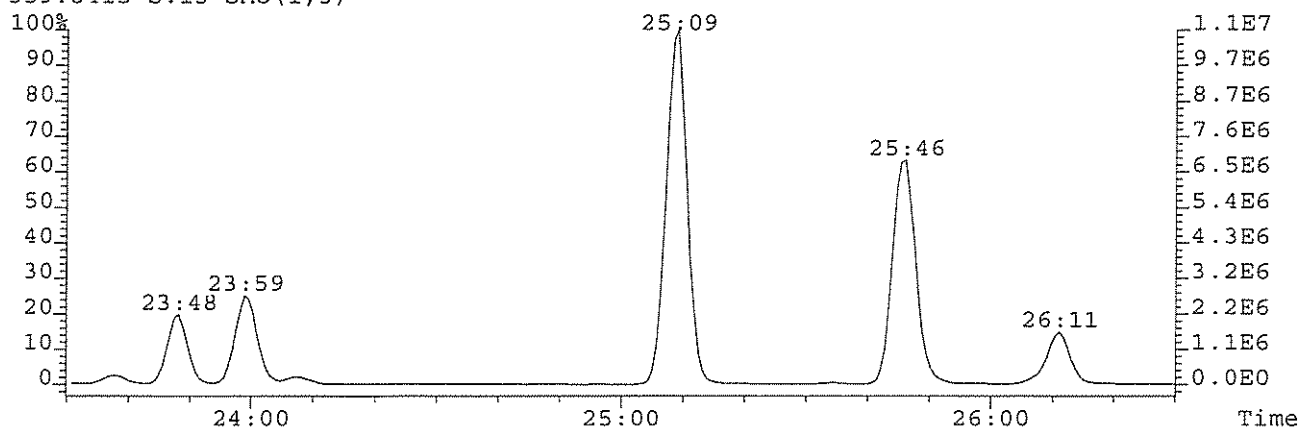
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130713 #1-2898 Acq:13-JUL-2013 20:17:59 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:RH-12ms(mP) Text:XE13 0960 2 1/100 Exp:RH-MP11



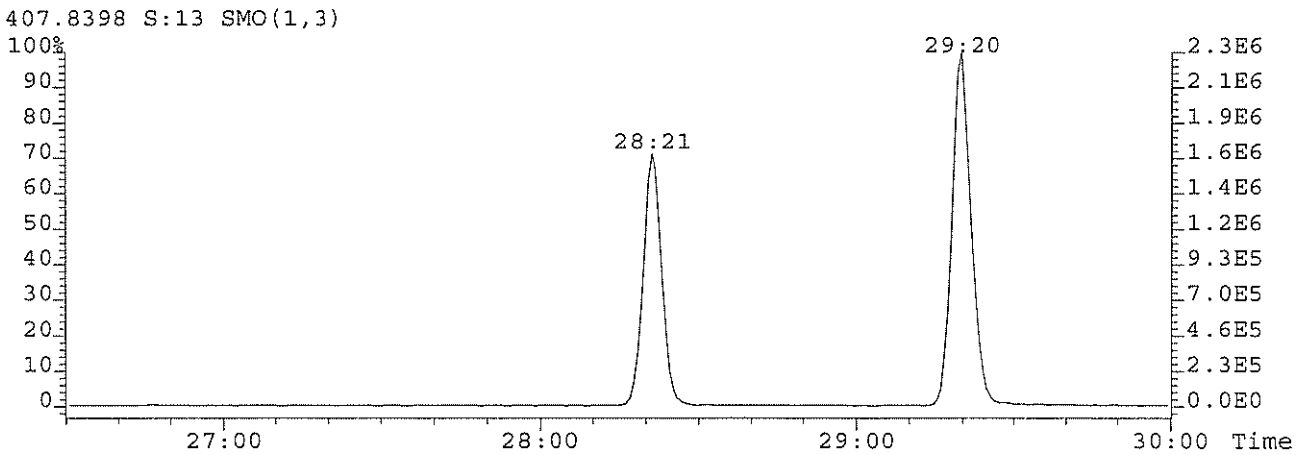
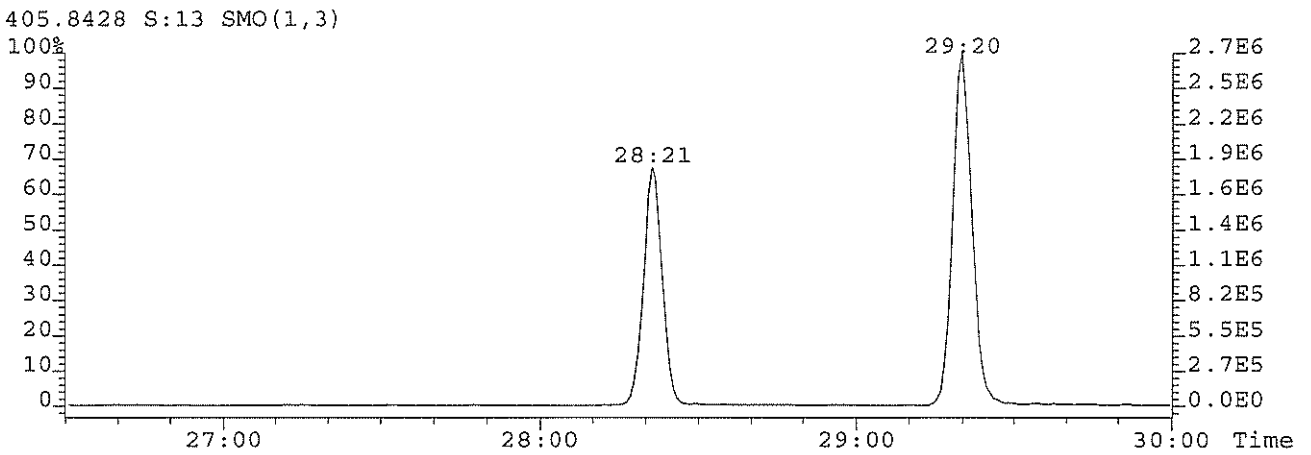
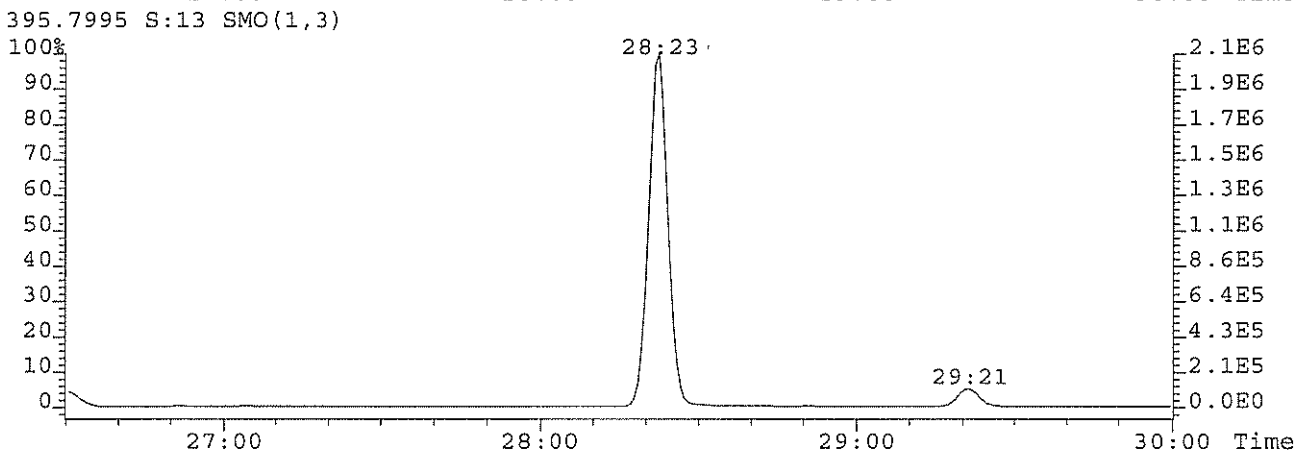
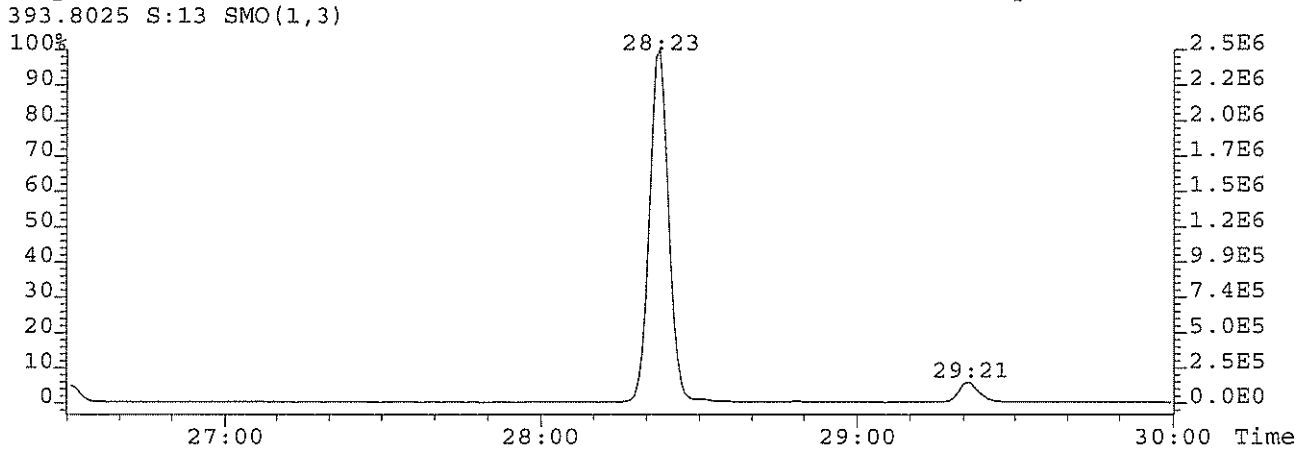
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130713 #1-2898 Acq:13-JUL-2013 20:17:59 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:RH-12ms(mP) Text:XE13 0960 2 1/100 Exp:RH-MP11  
359.8415 S:13 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130713 #1-2898 Acq:13-JUL-2013 20:17:59 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#13 File Text:RH-12ms(mP) Text:XE13 0960 2 1/100 Exp:RH-MP11

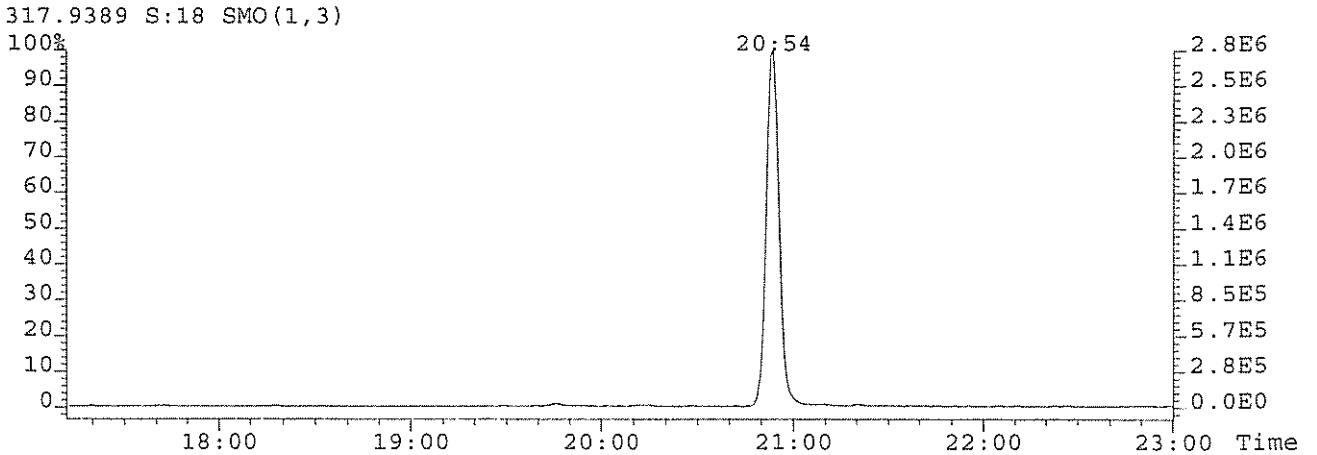
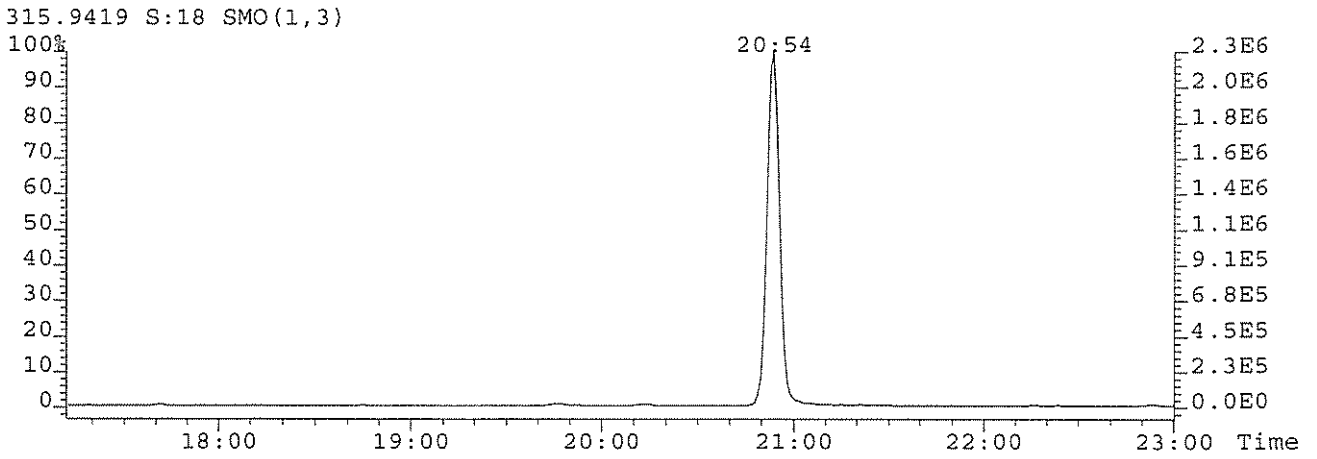
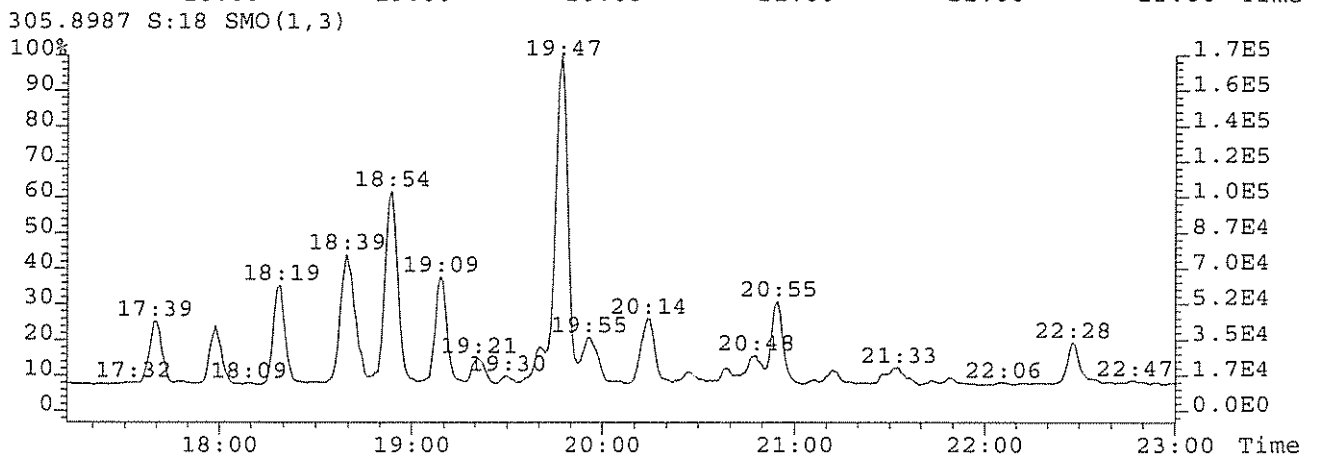
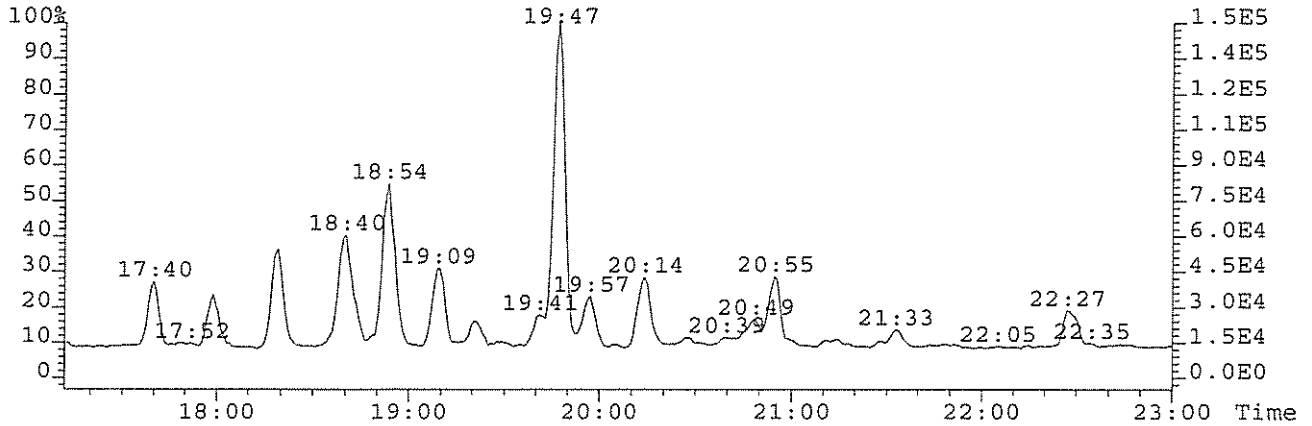


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)



試料管理番号	XE 130961
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.15

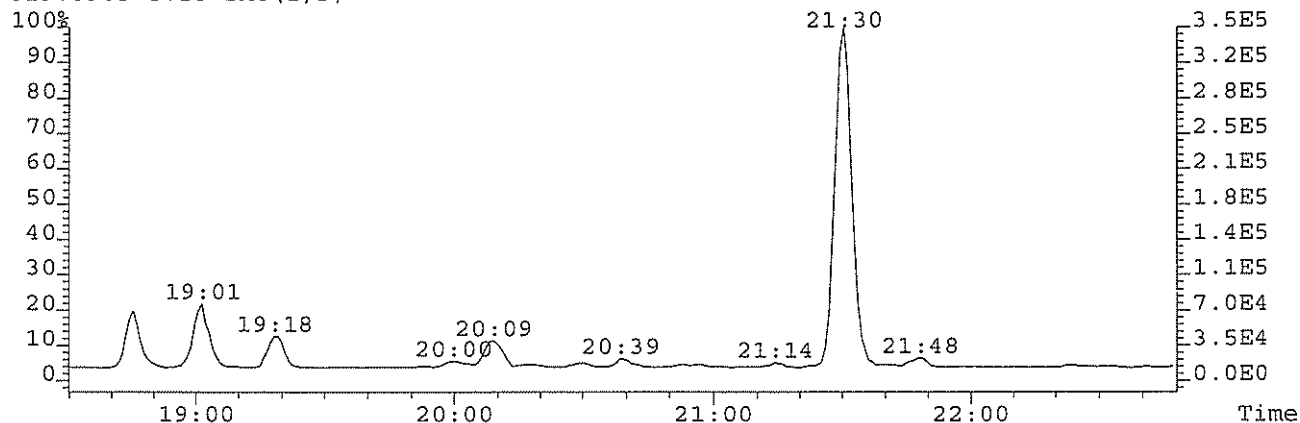
File:130712-2 #1-1578 Acq:13-JUL-2013 05:49:57 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:BPX-DXN(4-6DXN) Text:XE13 0961 Exp:BPX04  
303.9016 S:18 SMO(1,3)



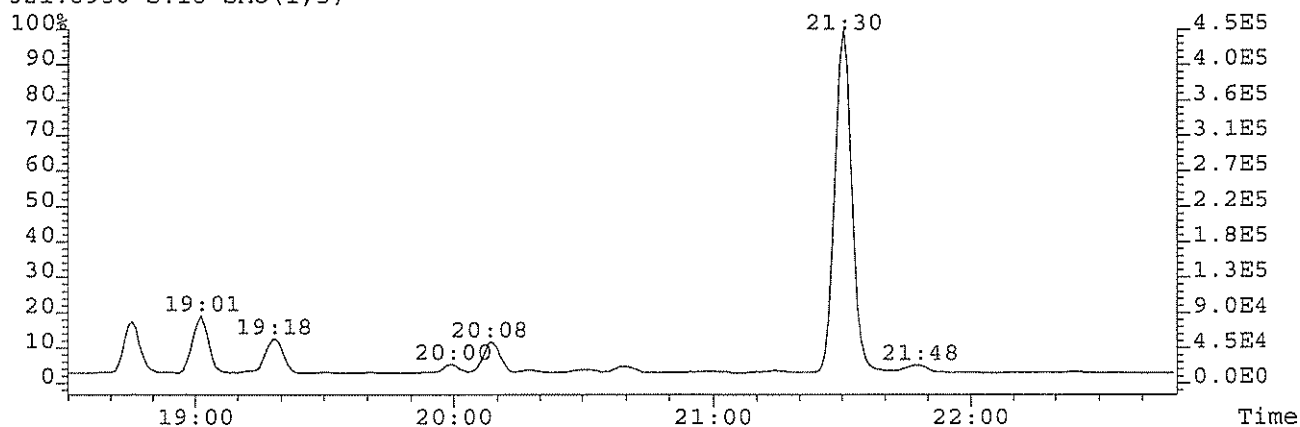
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 05:49:57 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:BPX-DXN(4-6DXN) Text:XE13 0961 Exp:BPX04

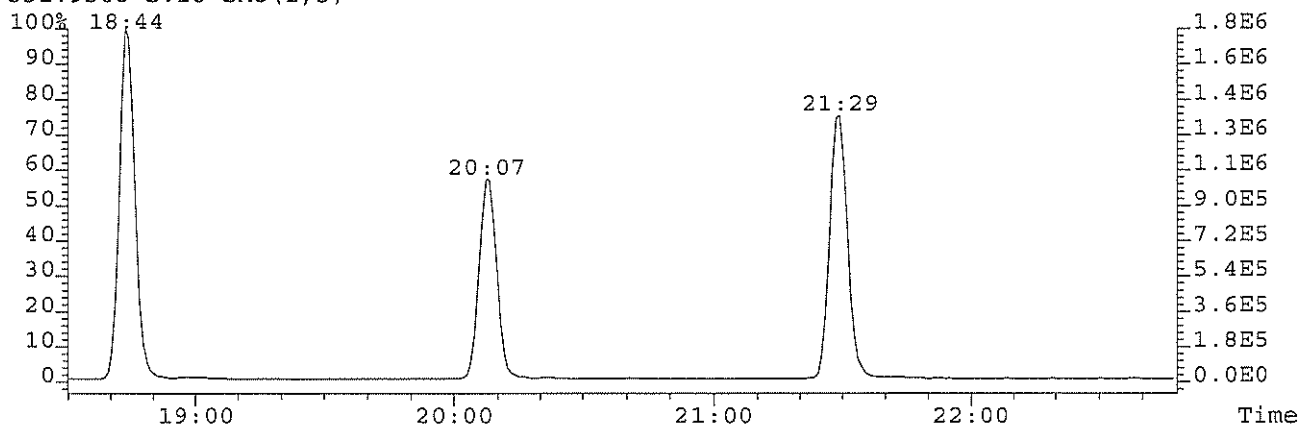
319.8965 S:18 SMO(1,3)



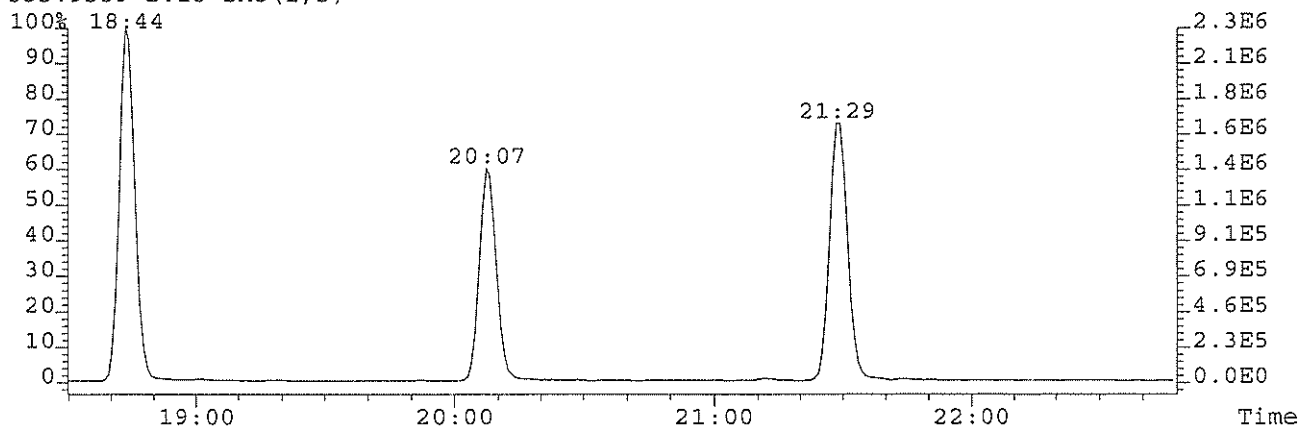
321.8936 S:18 SMO(1,3)



331.9368 S:18 SMO(1,3)

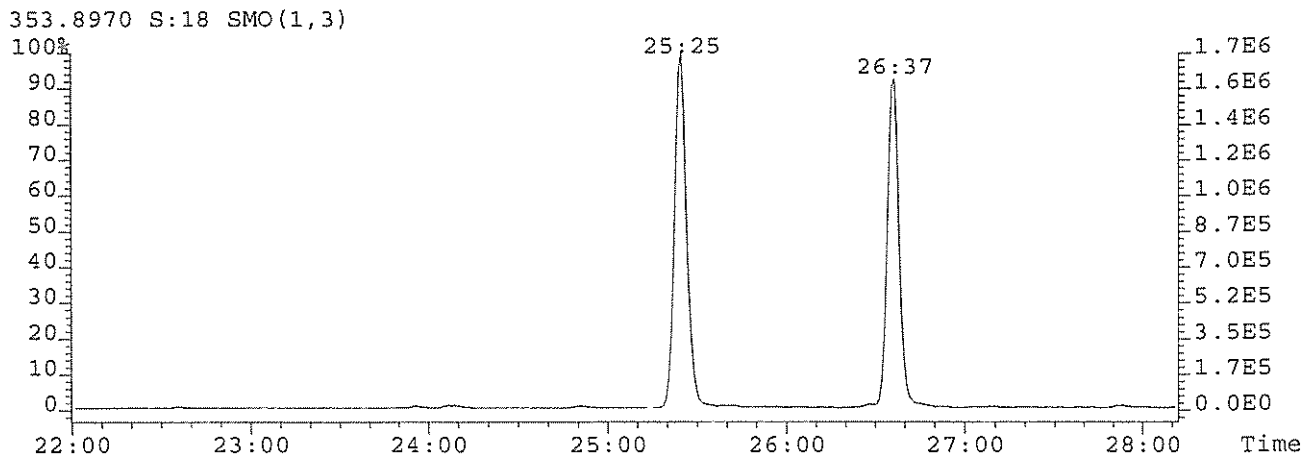
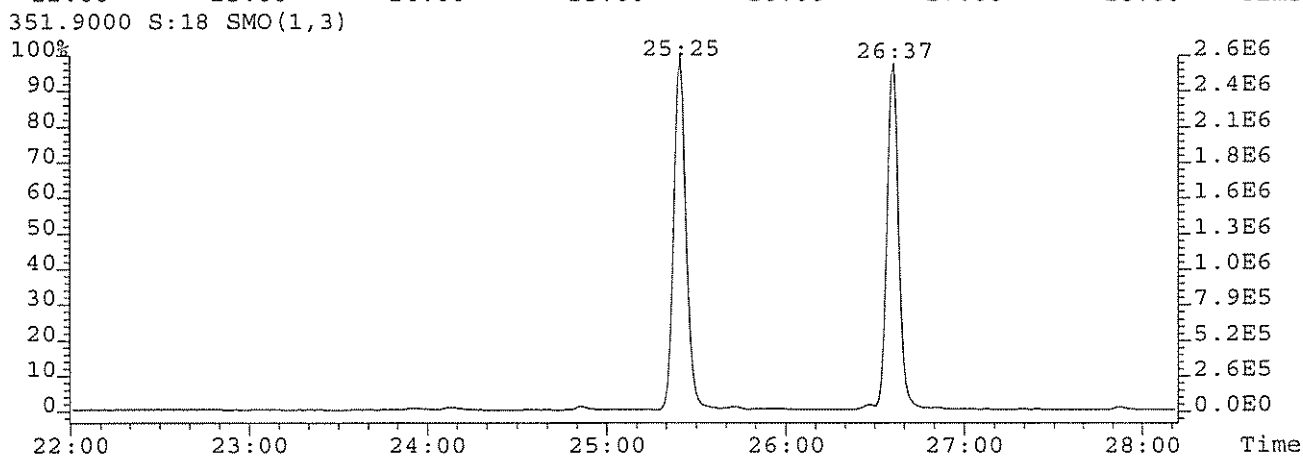
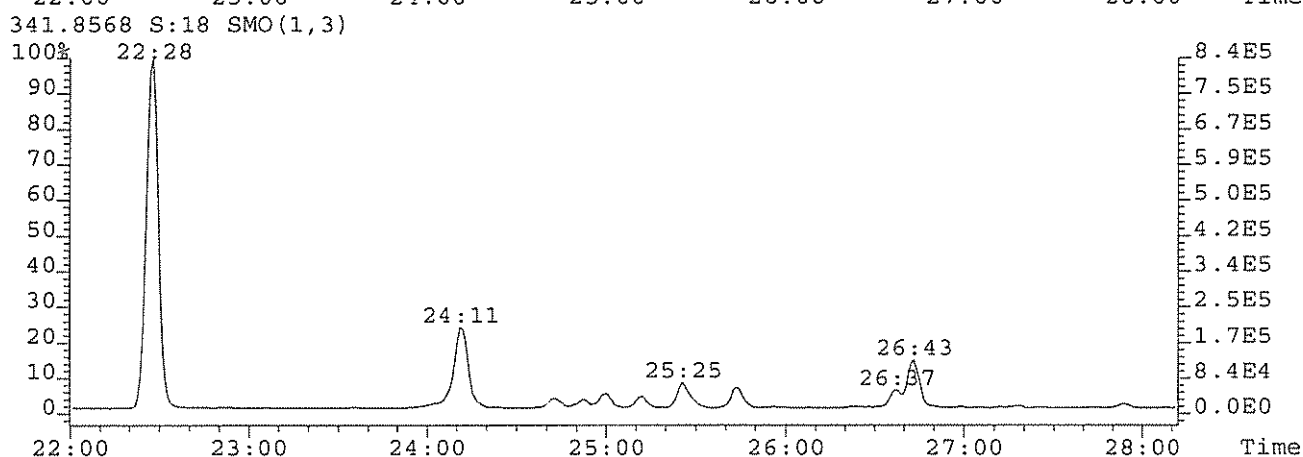
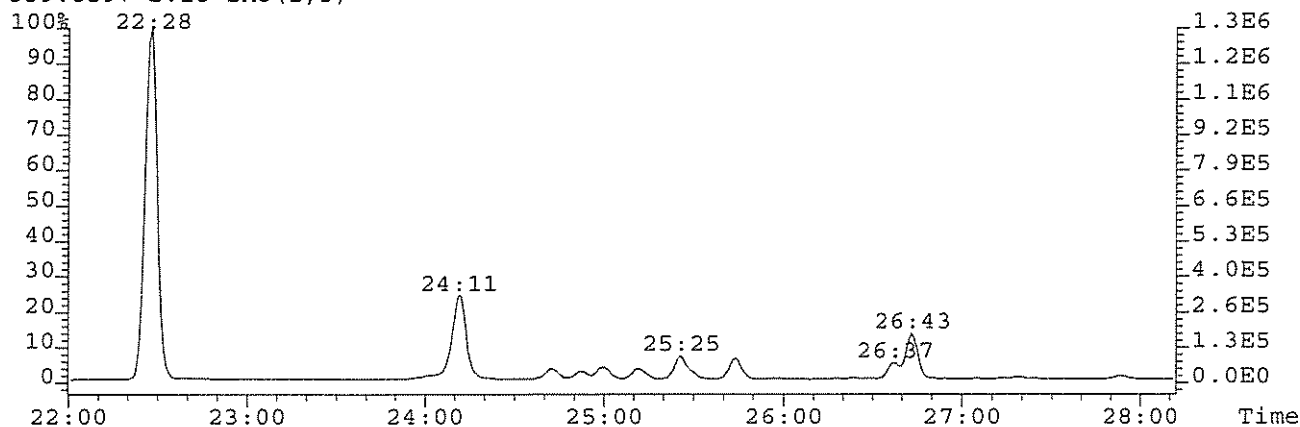


333.9339 S:18 SMO(1,3)



PCDDsクロマトグラム (2)  
(TeCDDs)

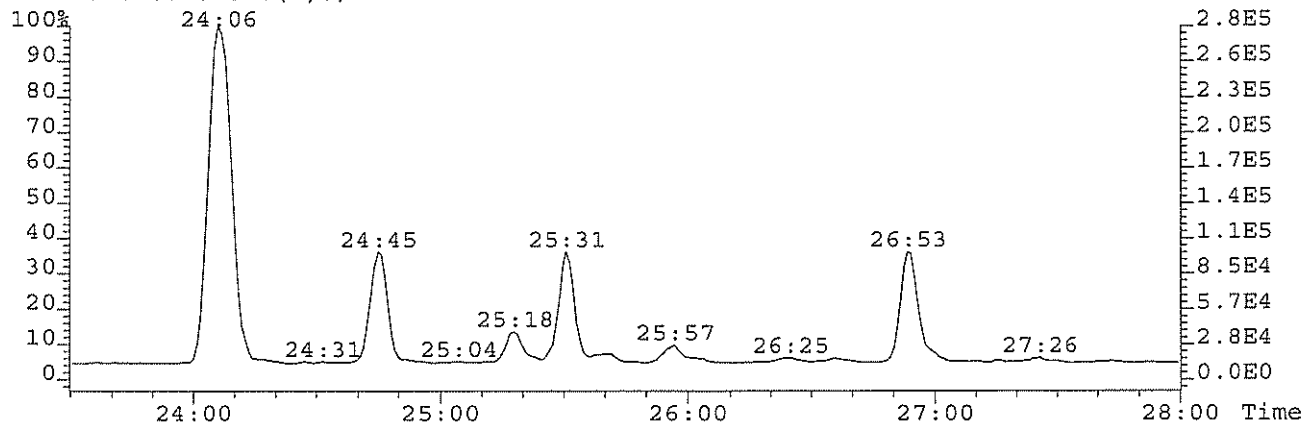
File:130712-2 #1-1578 Acq:13-JUL-2013 05:49:57 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:BPX-DXN(4-6DXN) Text:XE13 0961 Exp:BPX04  
339.8597 S:18 SMO(1,3)



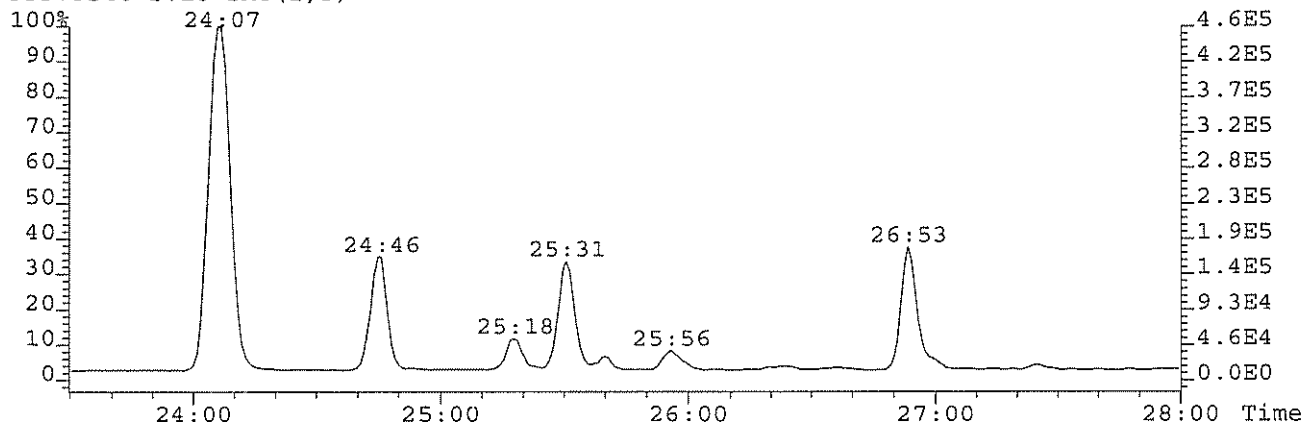
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 05:49:57 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:BPX-DXN(4-6DXN) Text:XE13 0961 Exp:BPX04

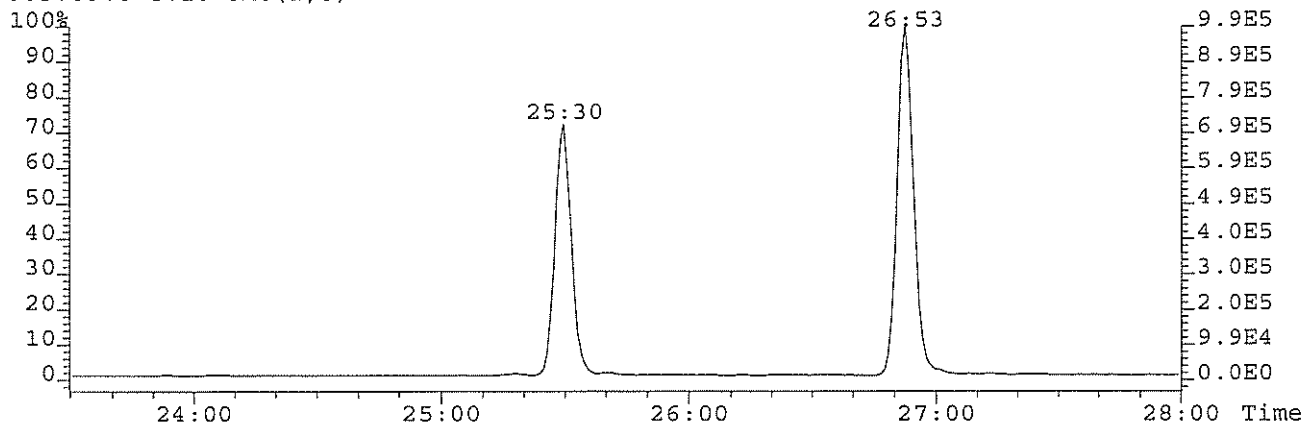
353.8576 S:18 SMO(1,3)



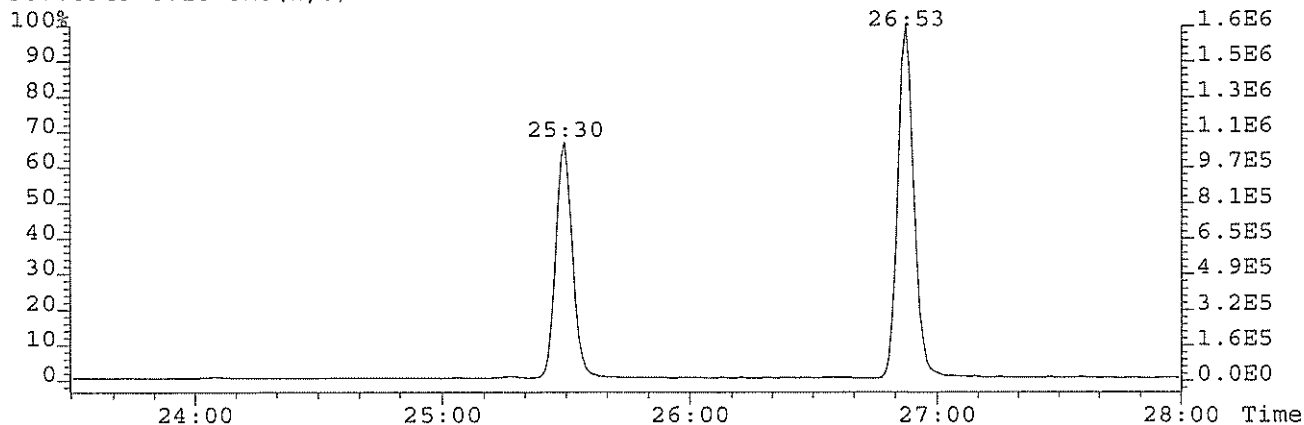
355.8546 S:18 SMO(1,3)



365.8978 S:18 SMO(1,3)

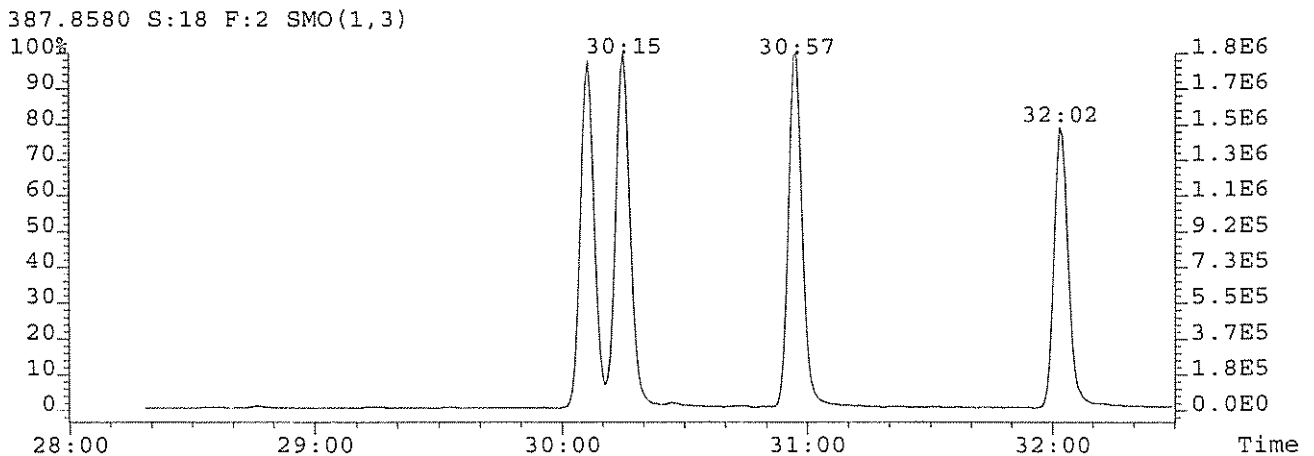
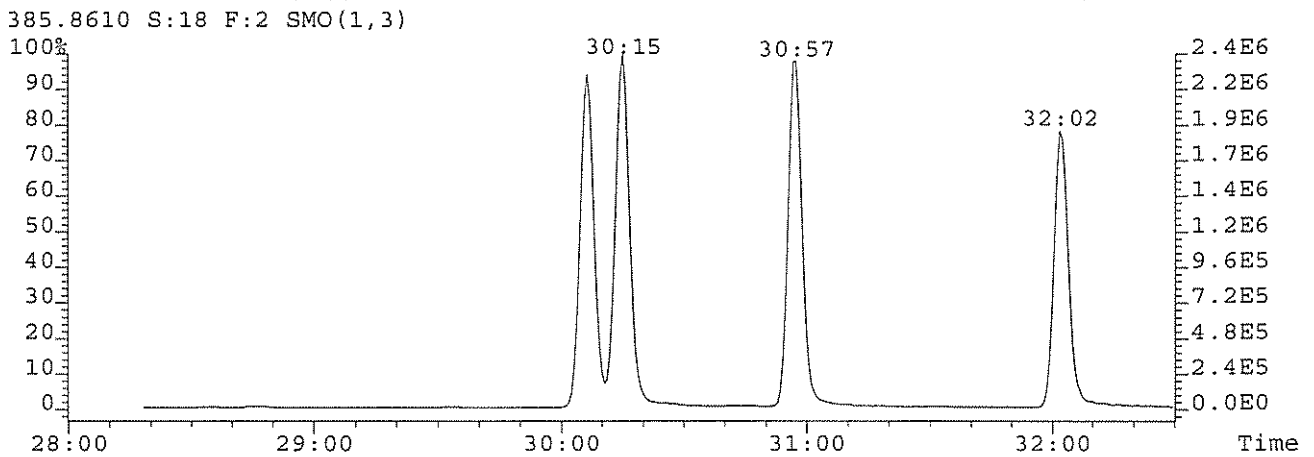
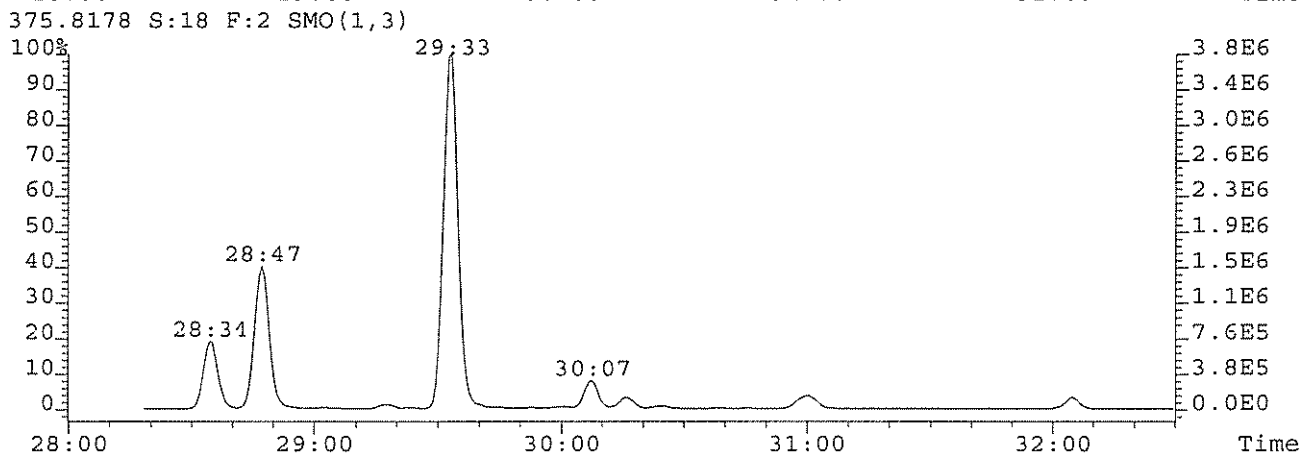
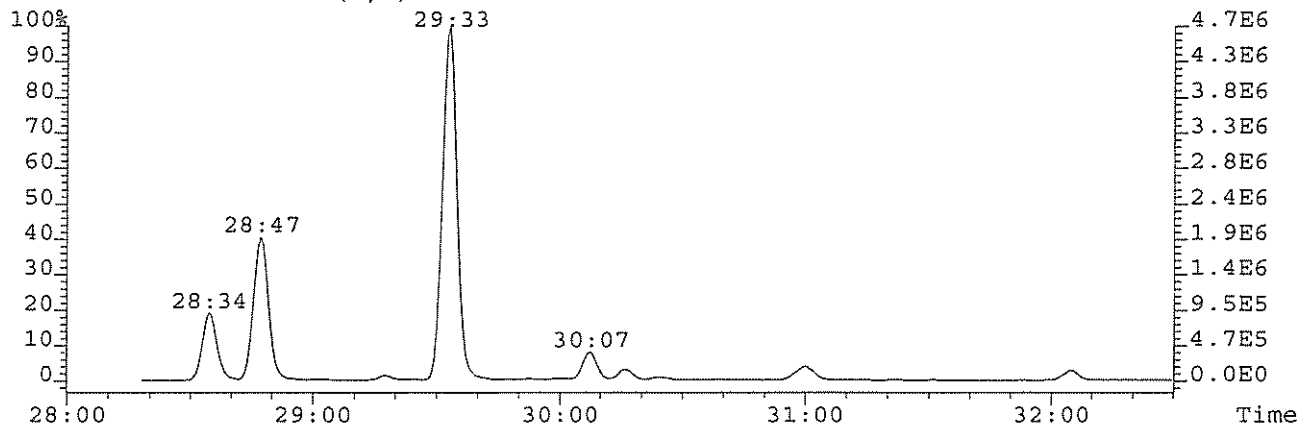


367.8949 S:18 SMO(1,3)



PCDDsクロマトグラム (4)  
(PeCDDs)

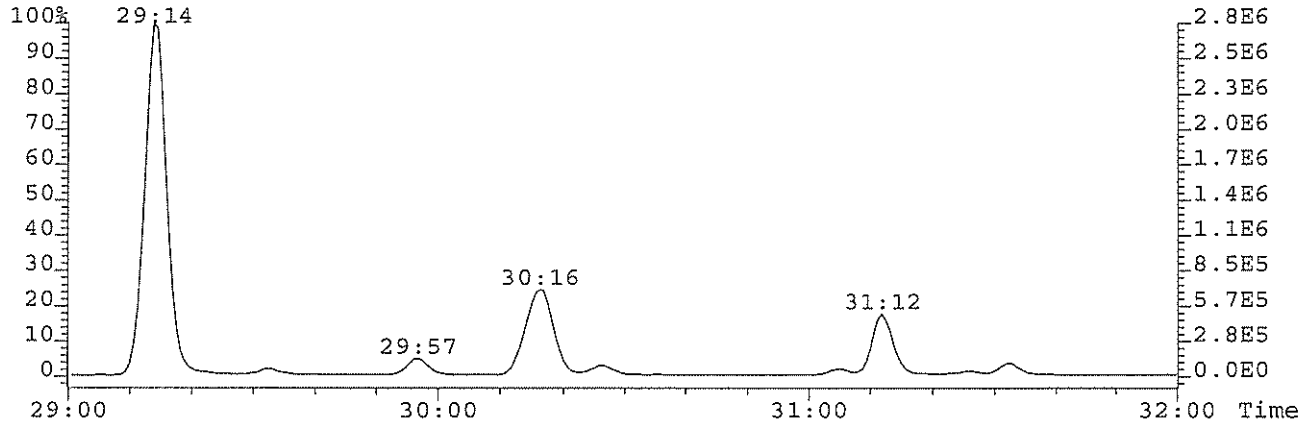
File:130712-2 #1-1118 Acq:13-JUL-2013 05:49:57 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:BPX-DXN(4-6DXN) Text:XE13 0961 Exp:BPX04  
373.8207 S:18 F:2 SMO(1,3)



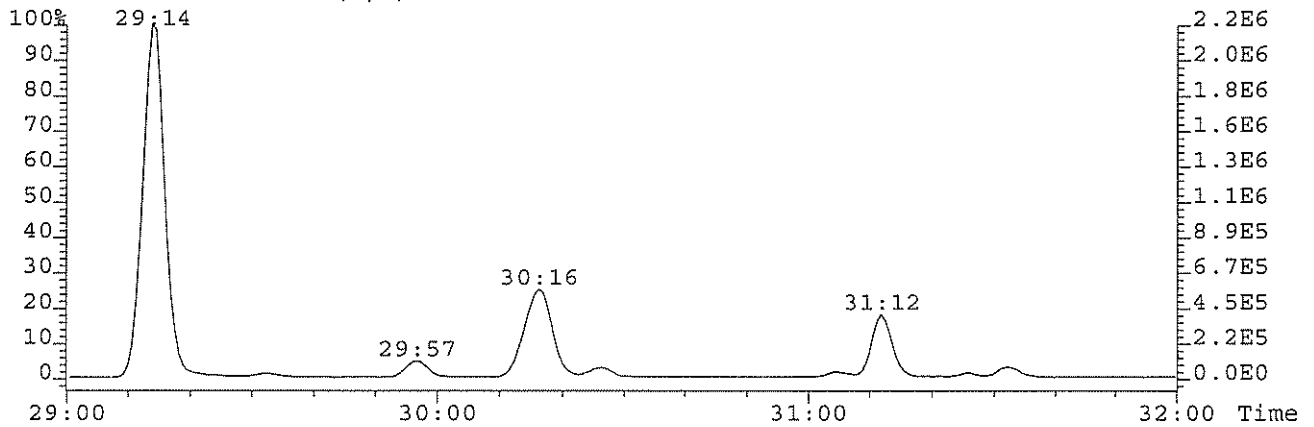
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1118 Acq:13-JUL-2013 05:49:57 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:BPX-DXN(4-6DXN) Text:XE13 0961 Exp:BPX04

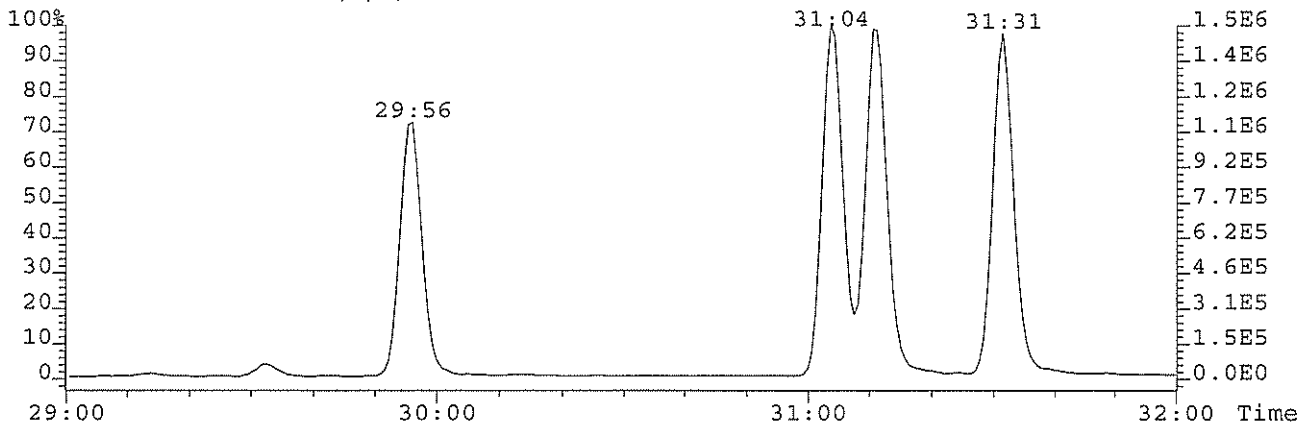
389.8156 S:18 F:2 SMO(1,3)



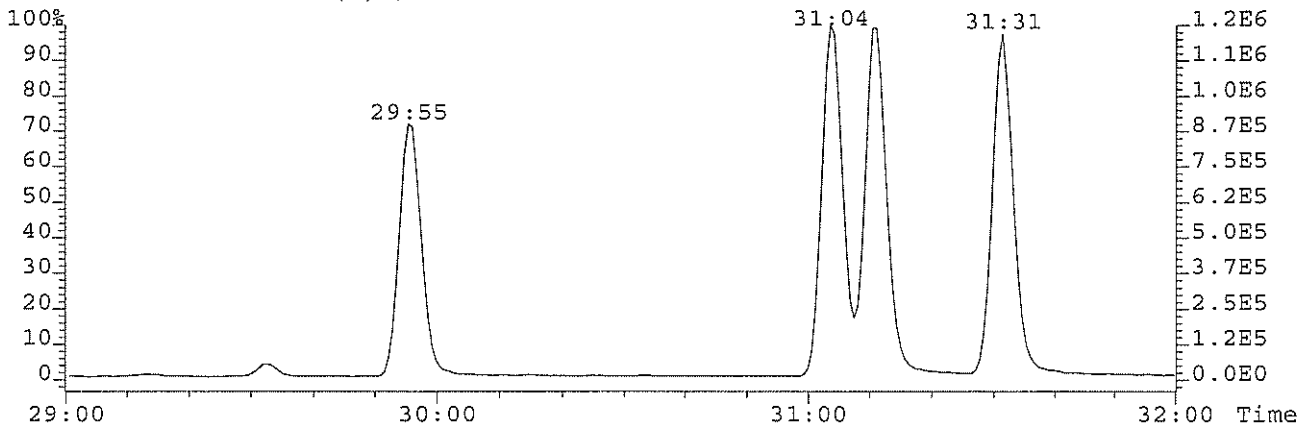
391.8127 S:18 F:2 SMO(1,3)



401.8559 S:18 F:2 SMO(1,3)

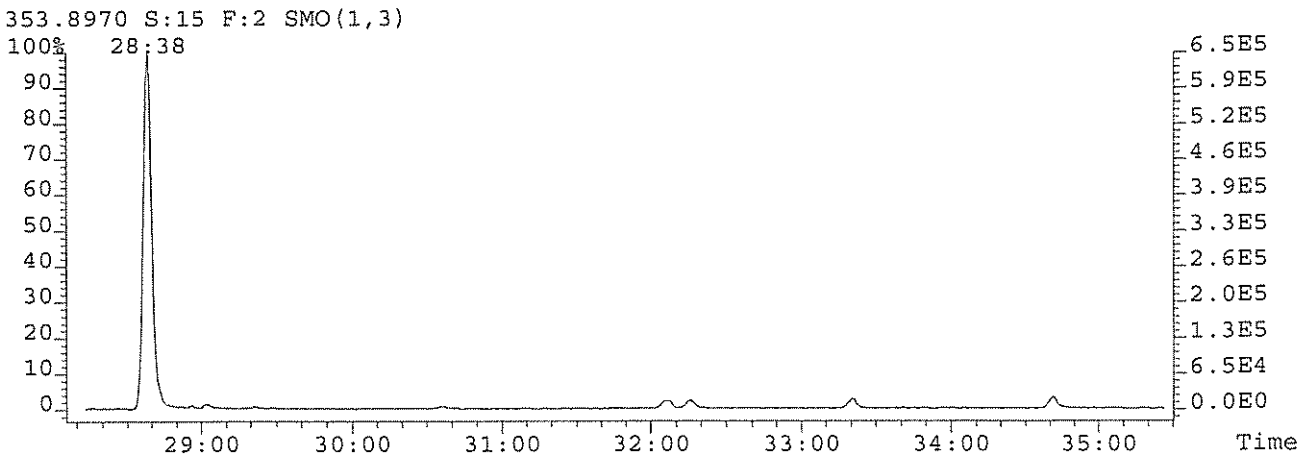
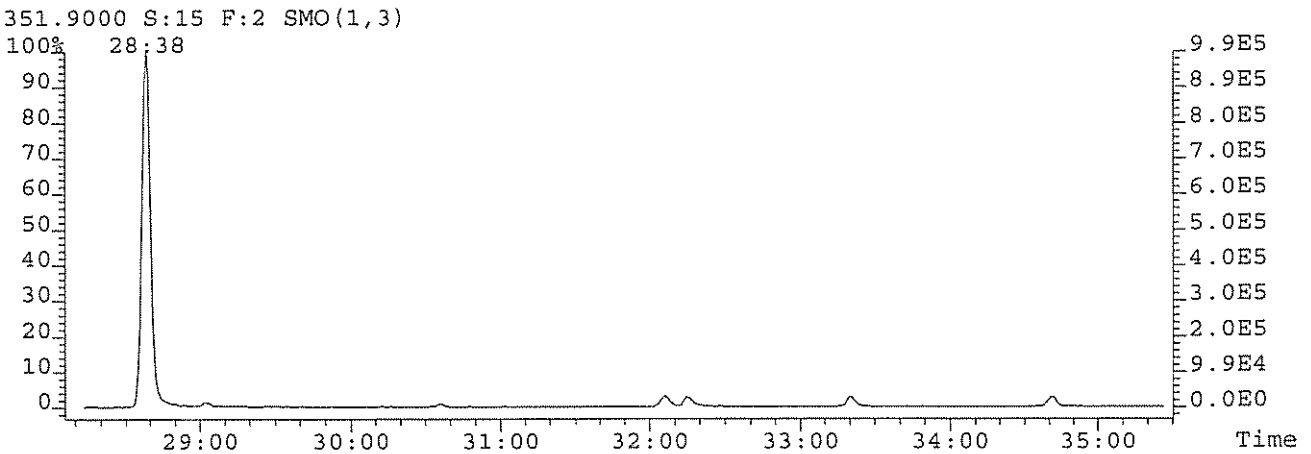
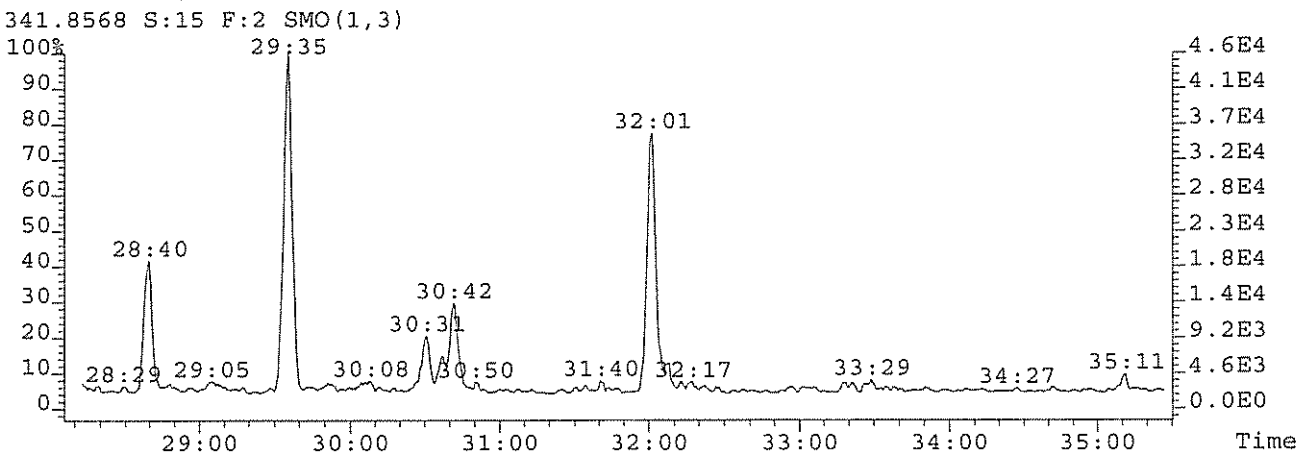
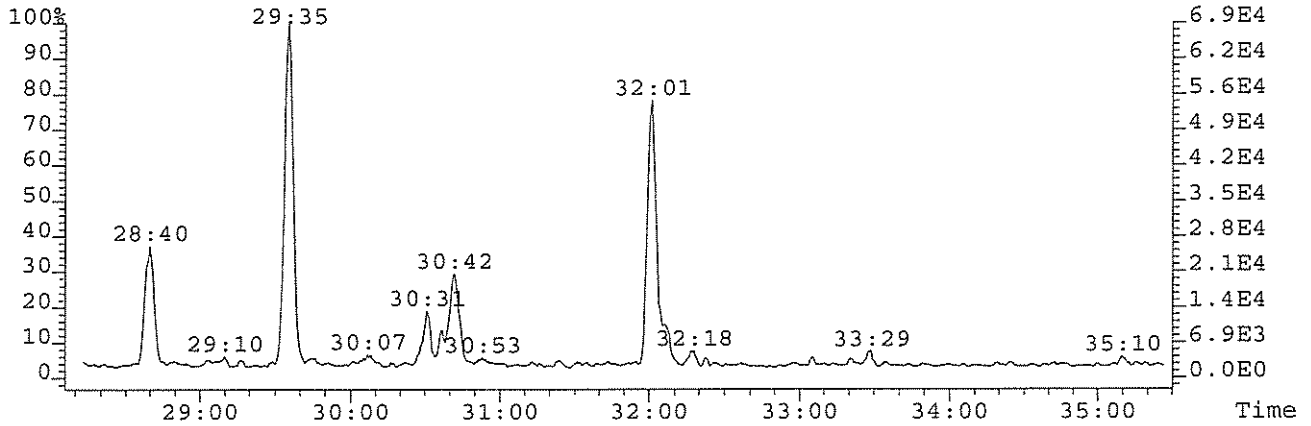


403.8530 S:18 F:2 SMO(1,3)



PCDDsクロマトグラム (6)  
(HxCDDs)

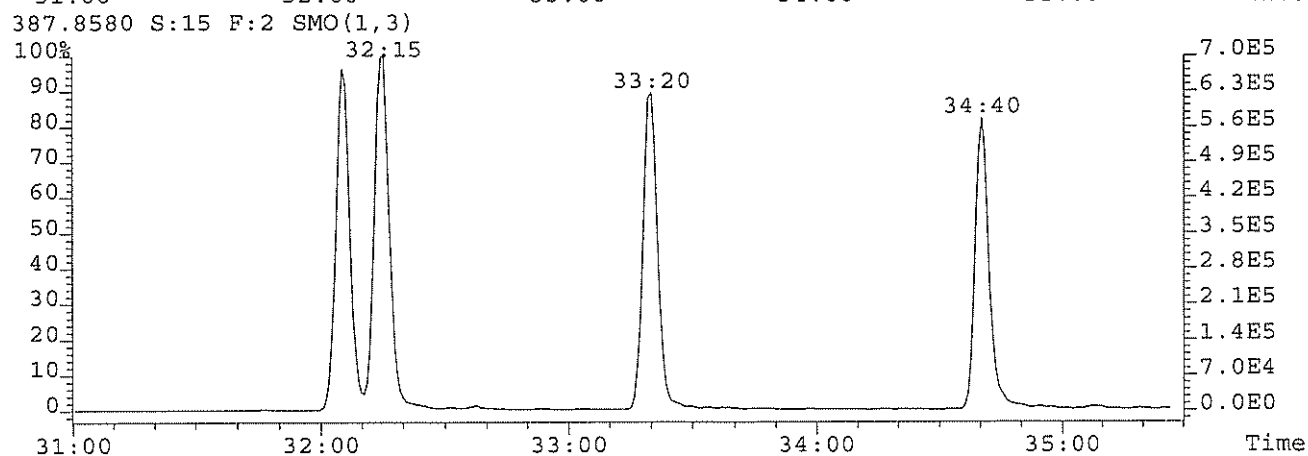
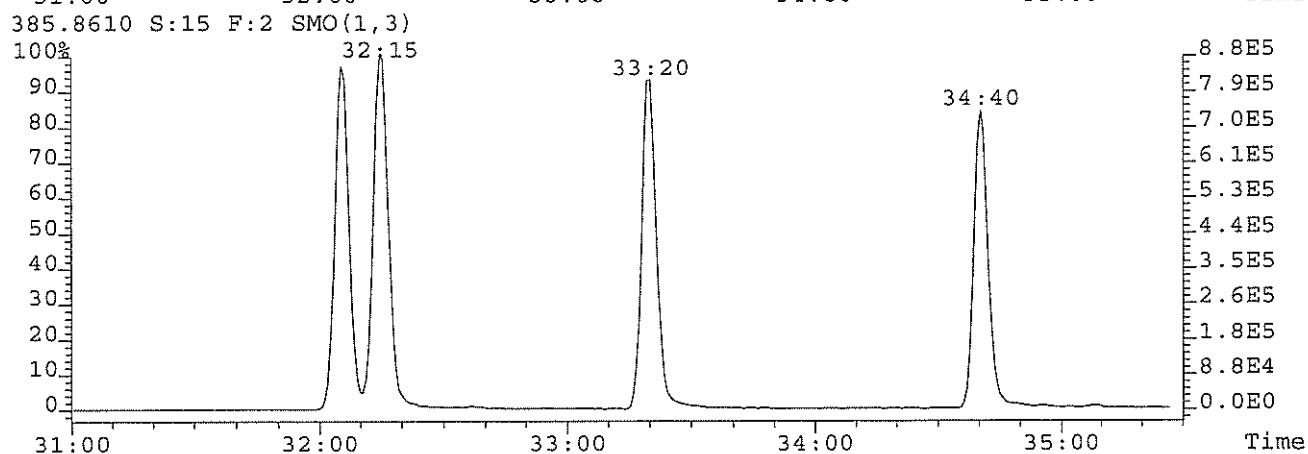
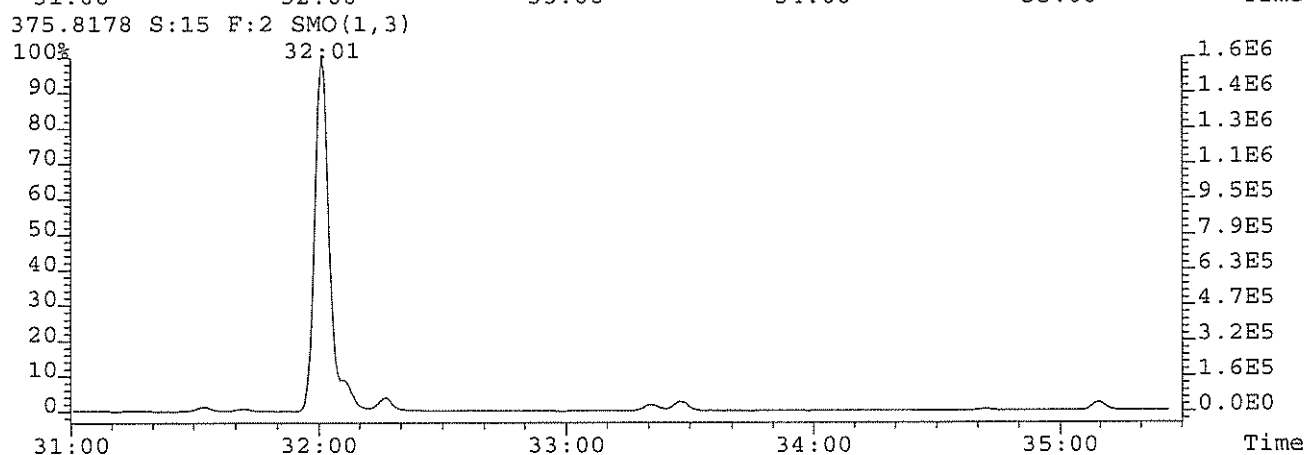
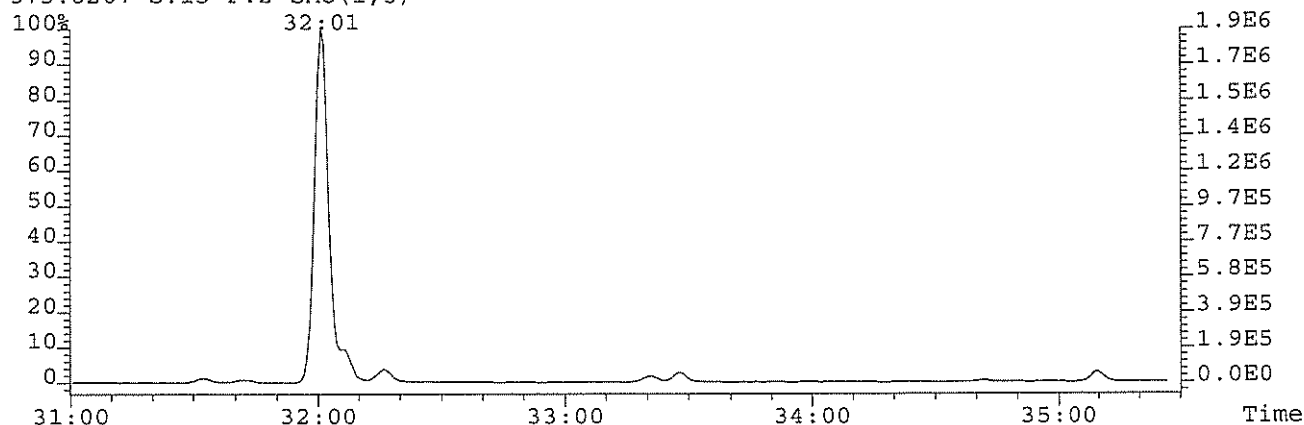
File:130713 #1-649 Acq:13-JUL-2013 23:48:23 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0961 3 Exp:RH-PD22  
339.8597 S:15 F:2 SMO(1,3)



PeCDFsクロマトグラム (7)  
(23478-PeCDF)

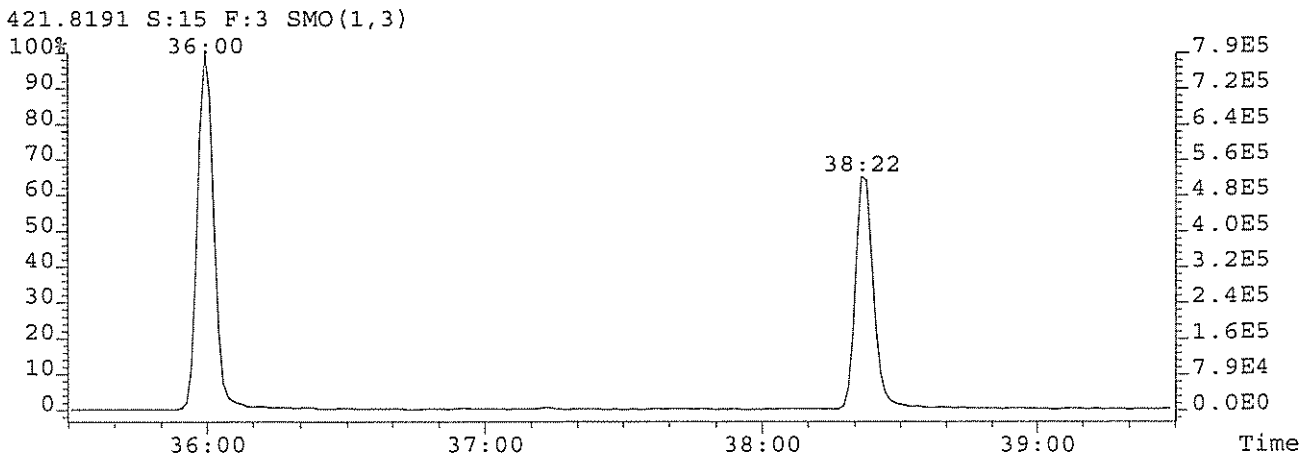
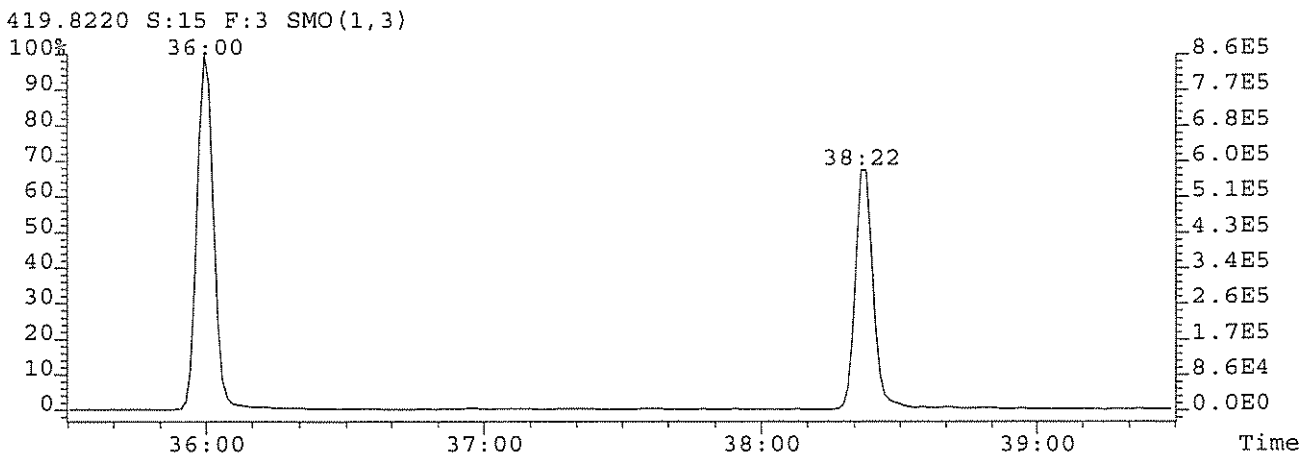
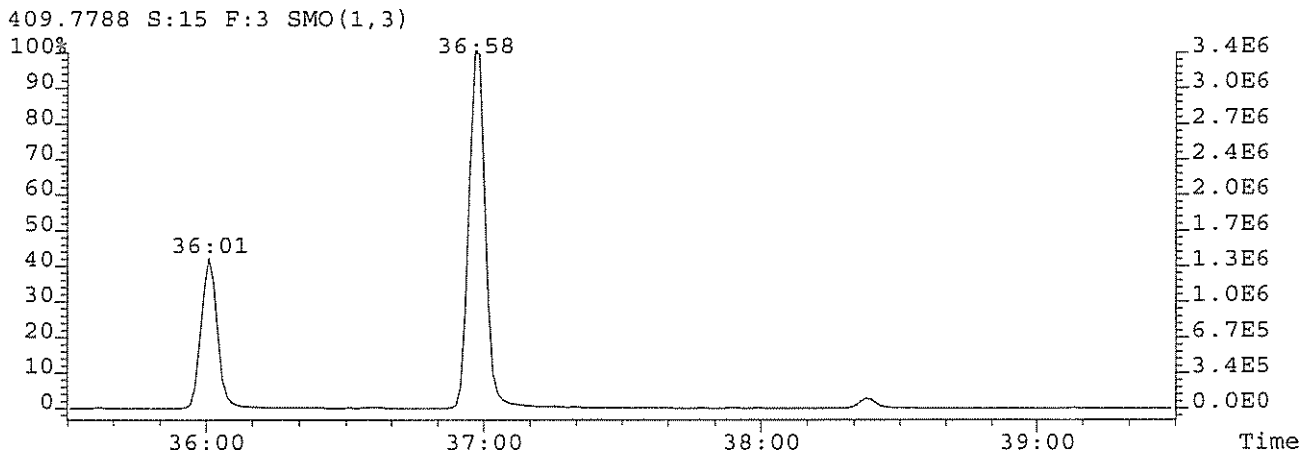
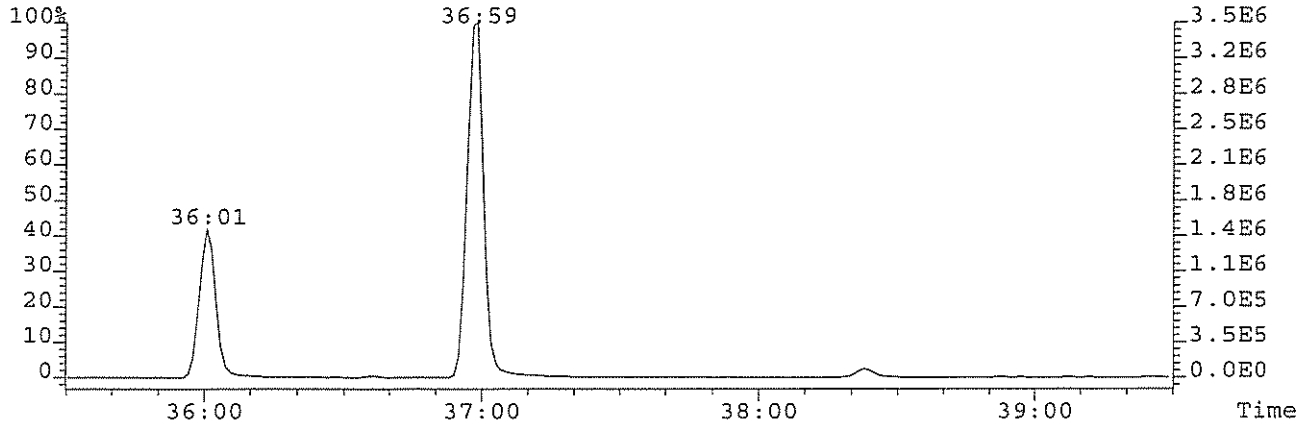


File:130713 #1-649 Acq:13-JUL-2013 23:48:23 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0961 3 Exp:RH-PD22  
373.8207 S:15 F:2 SMO(1,3)



HxCDFsクロマトグラム (8)  
(123789-HxCDF)

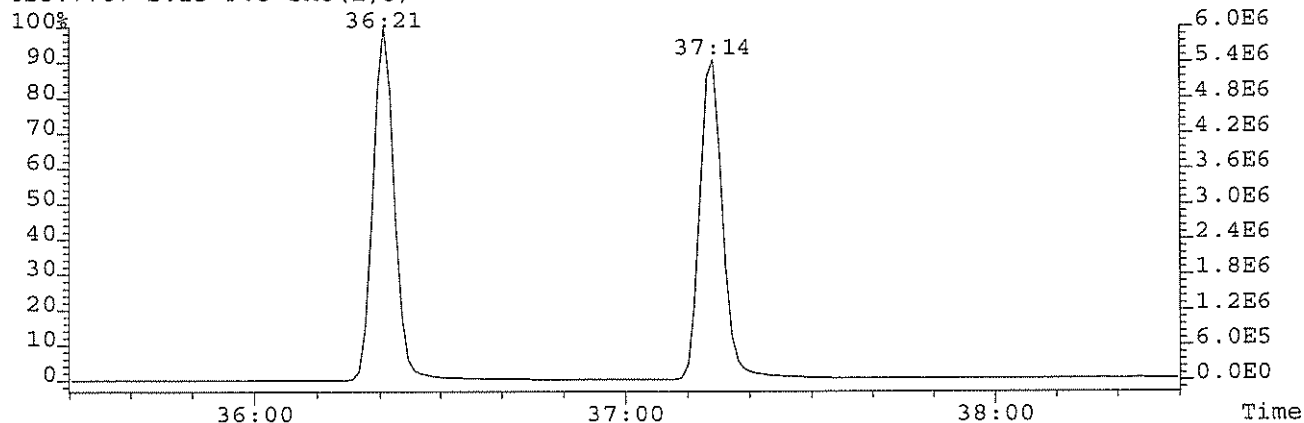
File:130713 #1-562 Acq:13-JUL-2013 23:48:23 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0961 3 Exp:RH-PD22  
407.7818 S:15 F:3 SMO(1,3)



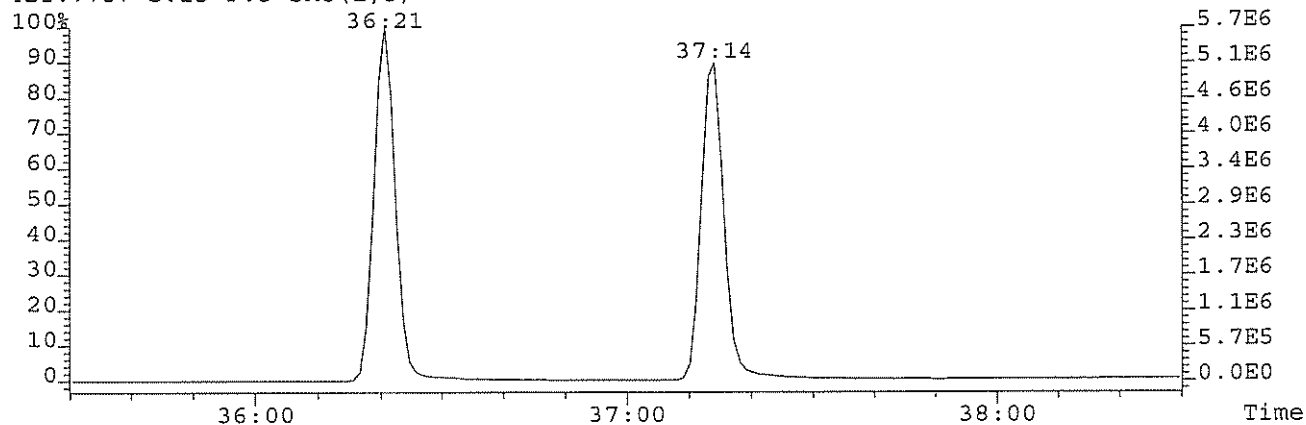
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130713 #1-562 Acq:13-JUL-2013 23:48:23 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0961 3 Exp:RH-PD22

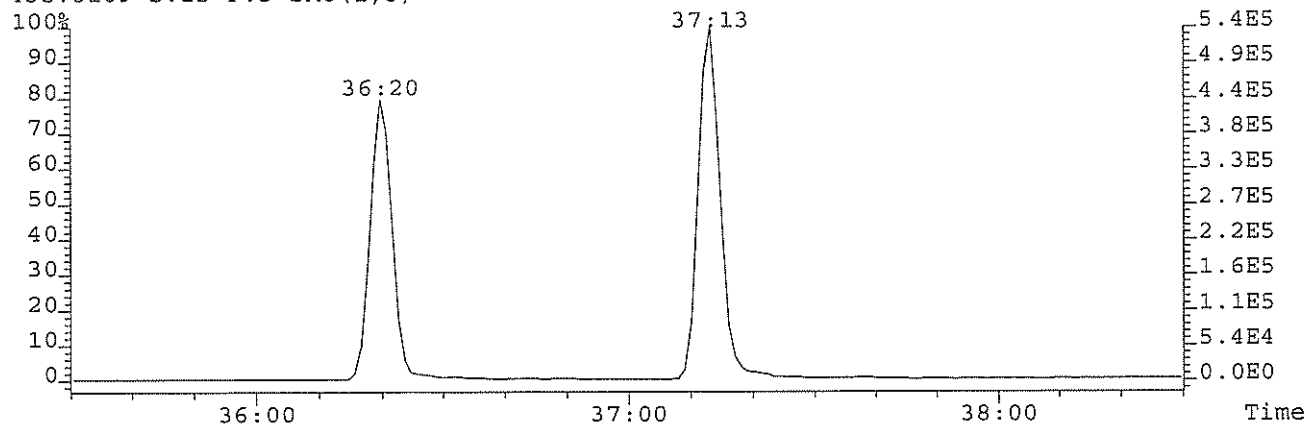
423.7767 S:15 F:3 SMO(1,3)



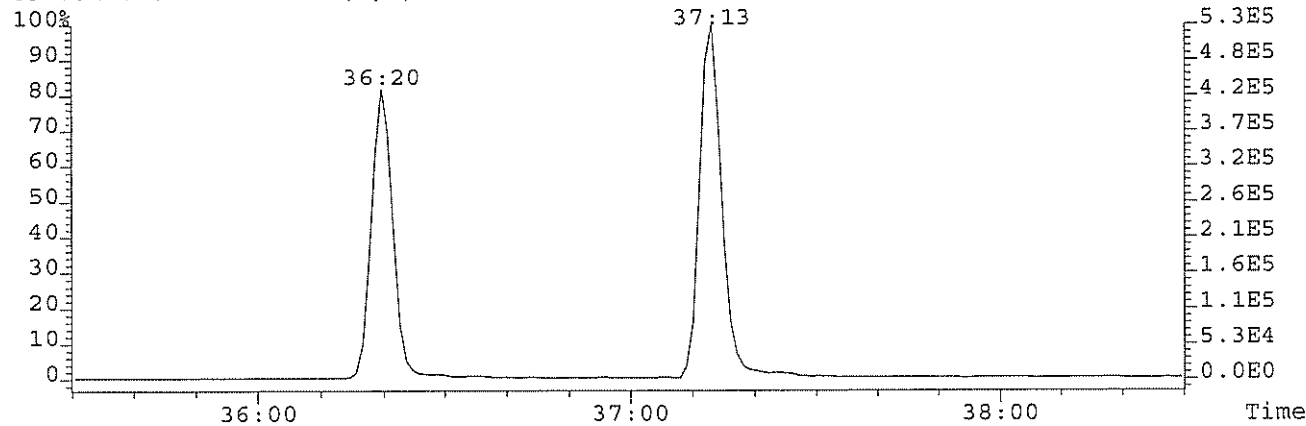
425.7737 S:15 F:3 SMO(1,3)



435.8169 S:15 F:3 SMO(1,3)



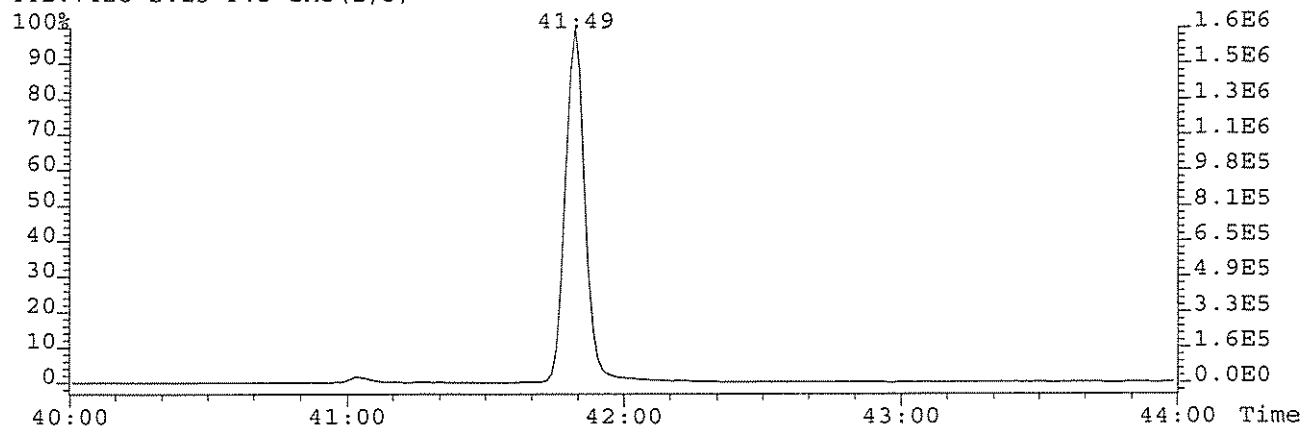
437.8140 S:15 F:3 SMO(1,3)



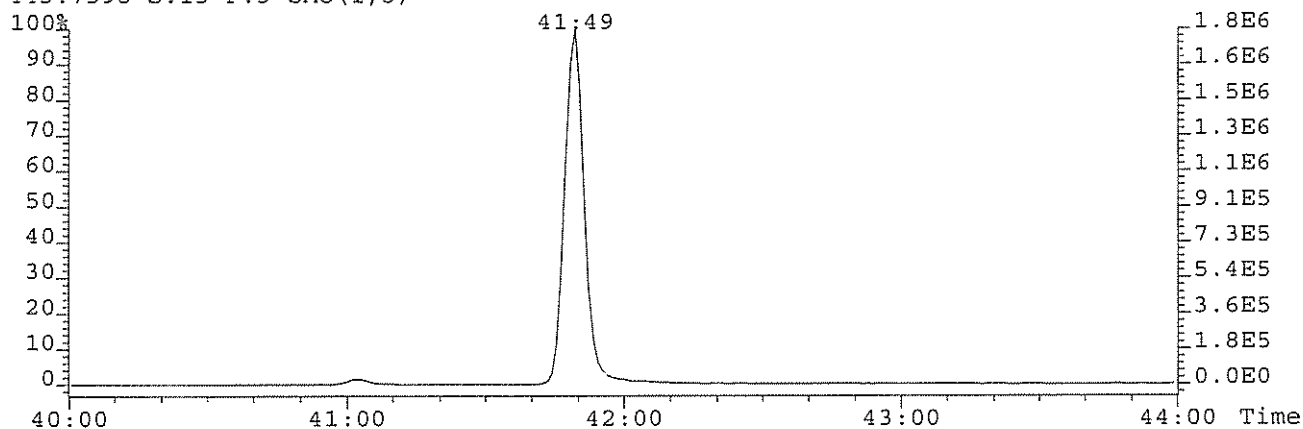
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130713 #1-562 Acq:13-JUL-2013 23:48:23 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0961 3 Exp:RH-PD22

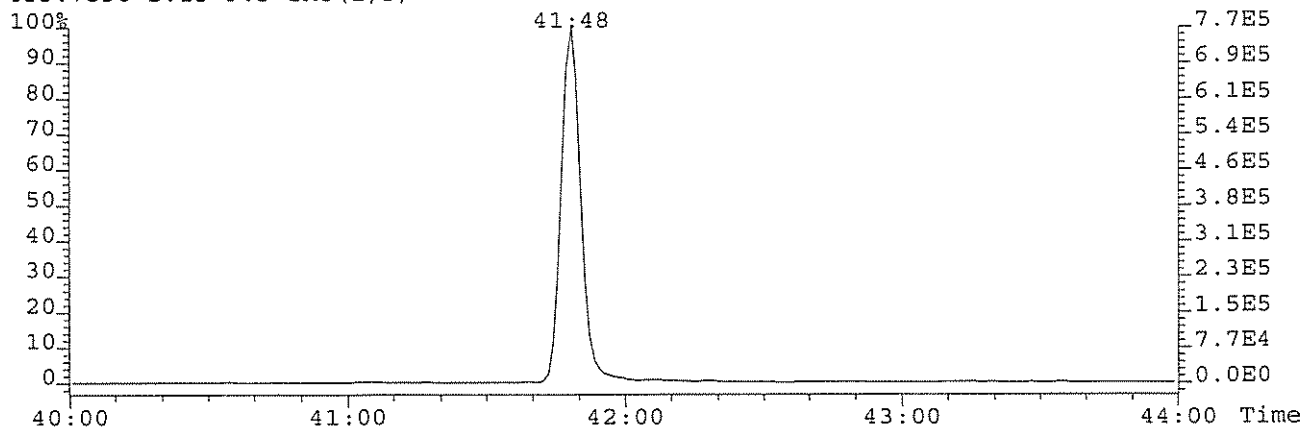
441.7428 S:15 F:3 SMO(1,3)



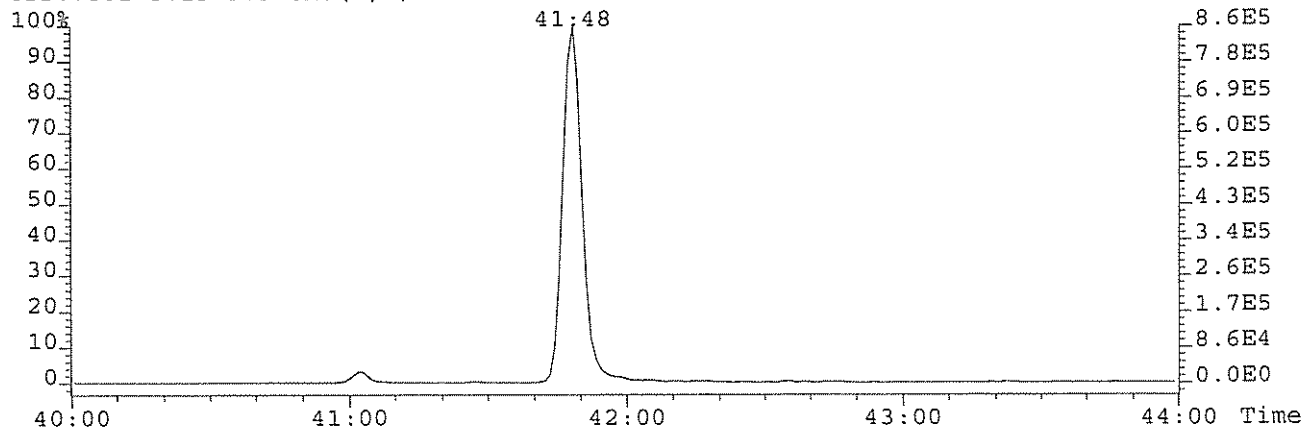
443.7398 S:15 F:3 SMO(1,3)



453.7830 S:15 F:3 SMO(1,3)

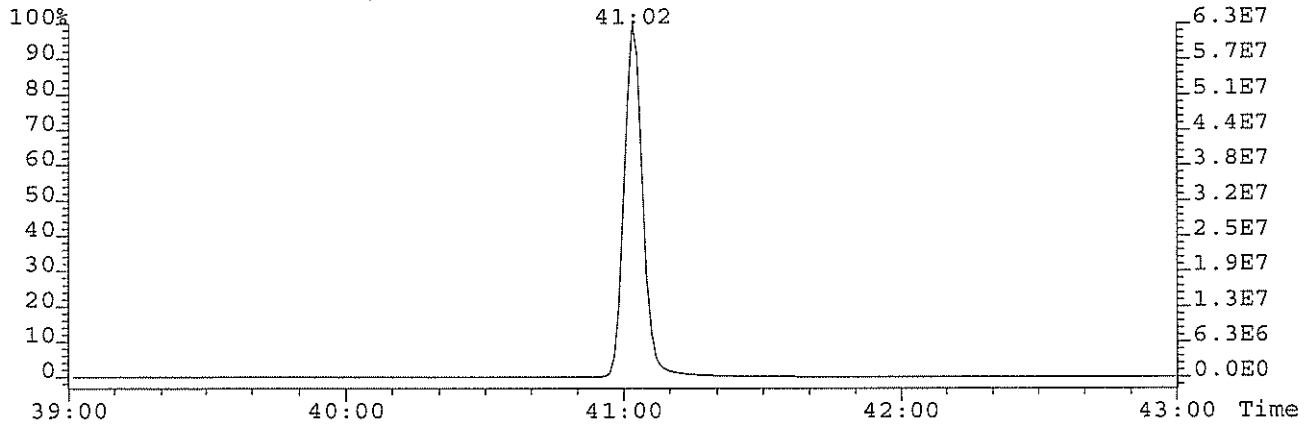


455.7801 S:15 F:3 SMO(1,3)

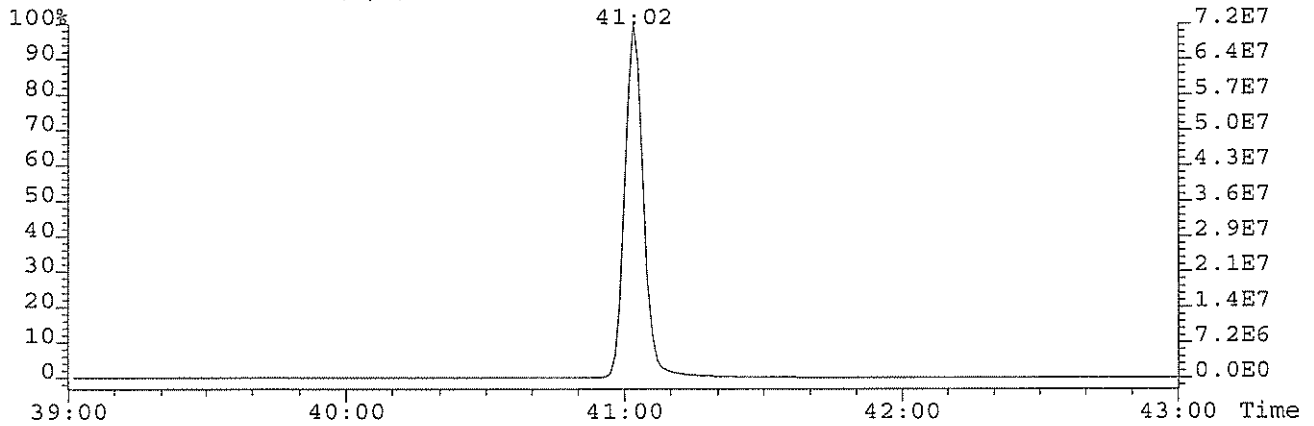


File:130713 #1-562 Acq:13-JUL-2013 23:48:23 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0961 3 Exp:RH-PD22

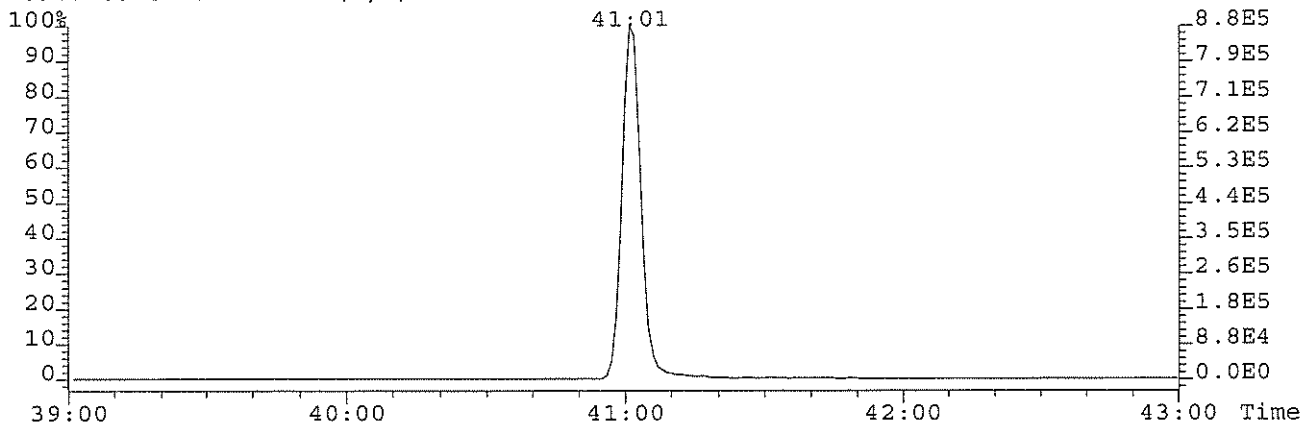
457.7377 S:15 F:3 SMO(1,3)



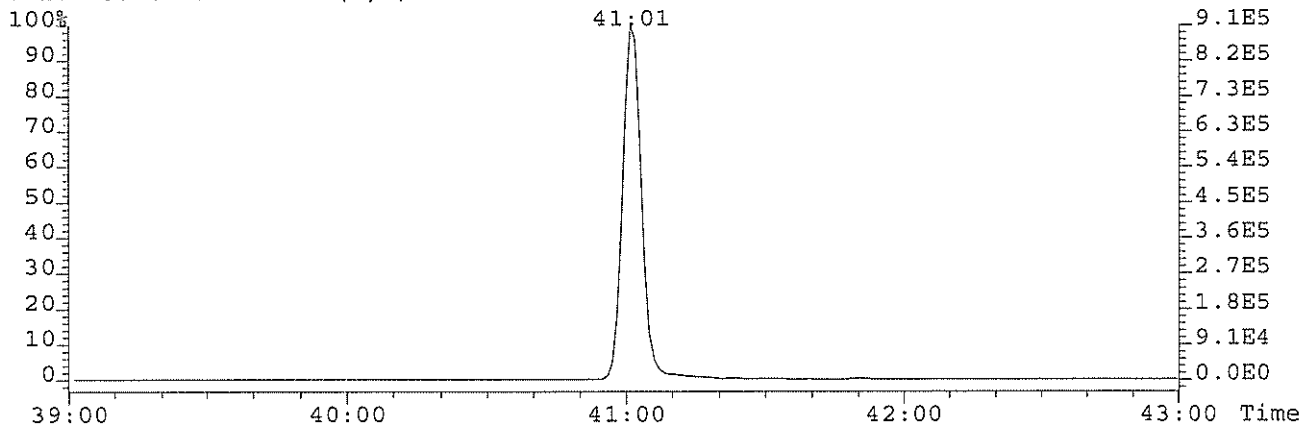
459.7348 S:15 F:3 SMO(1,3)



469.7780 S:15 F:3 SMO(1,3)

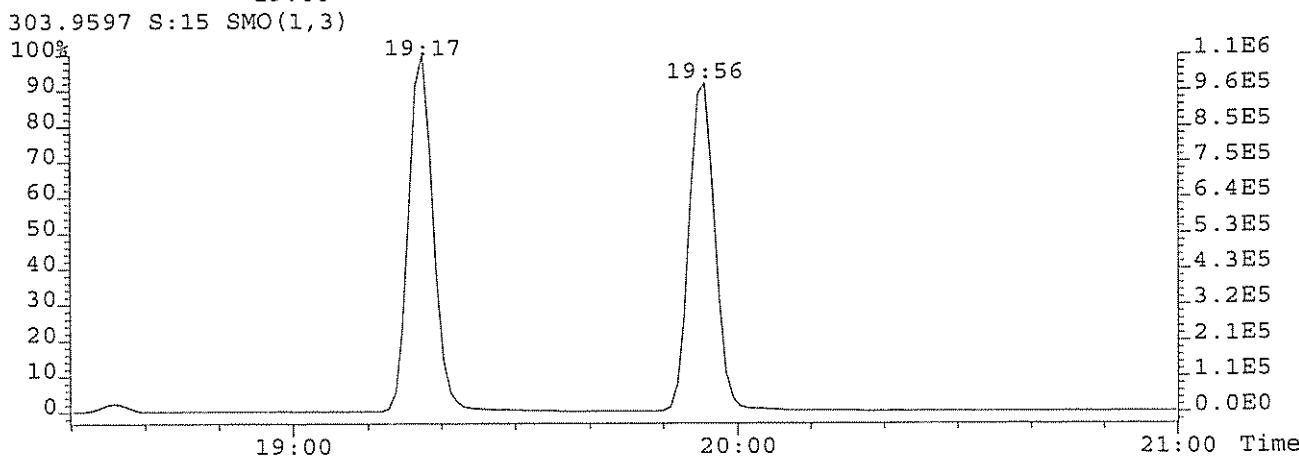
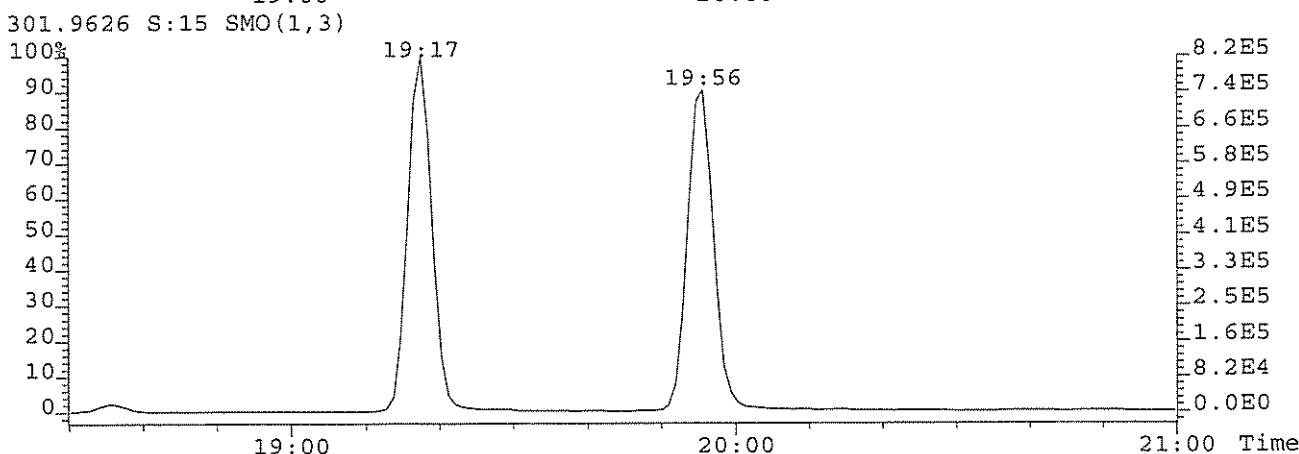
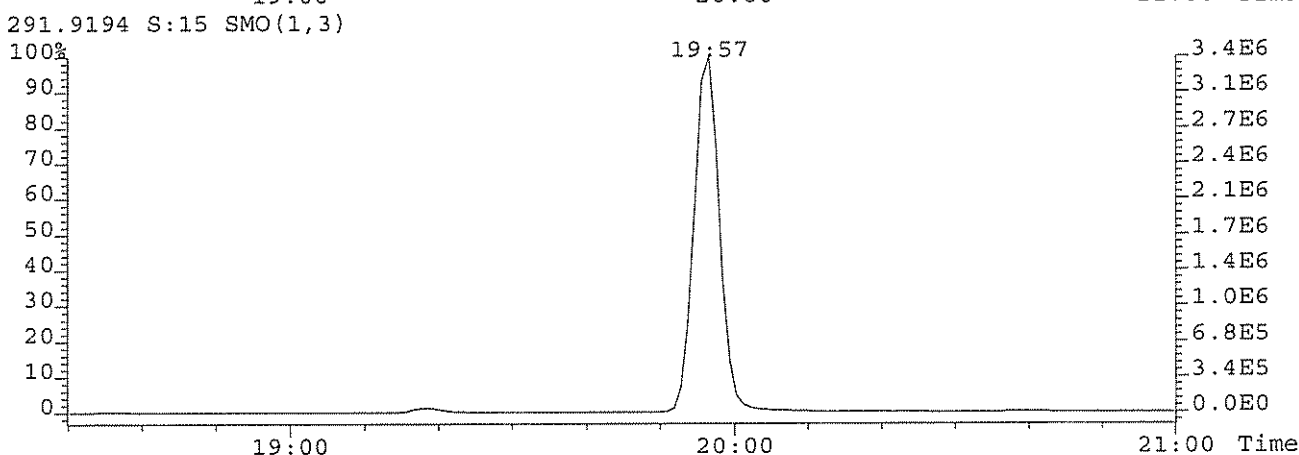
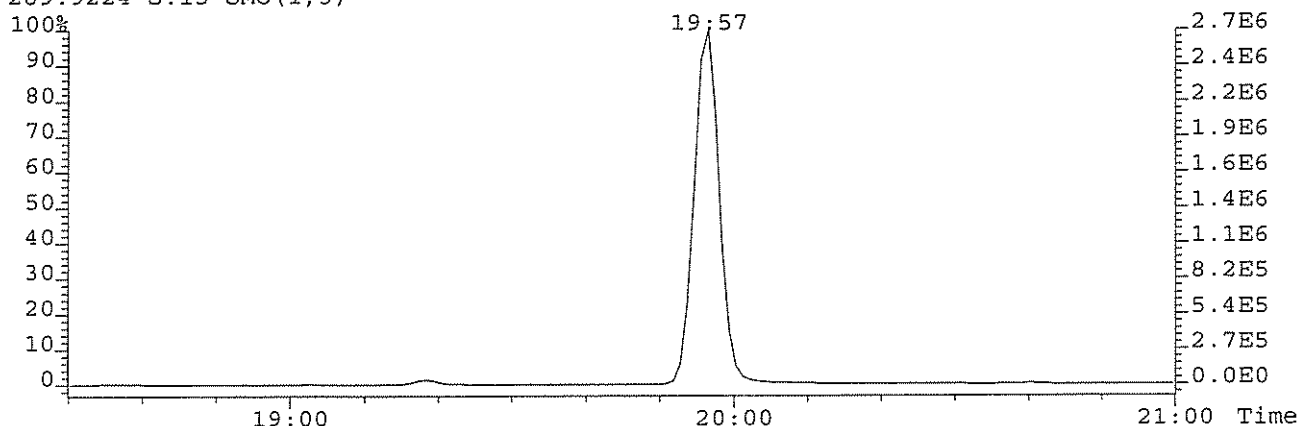


471.7750 S:15 F:3 SMO(1,3)



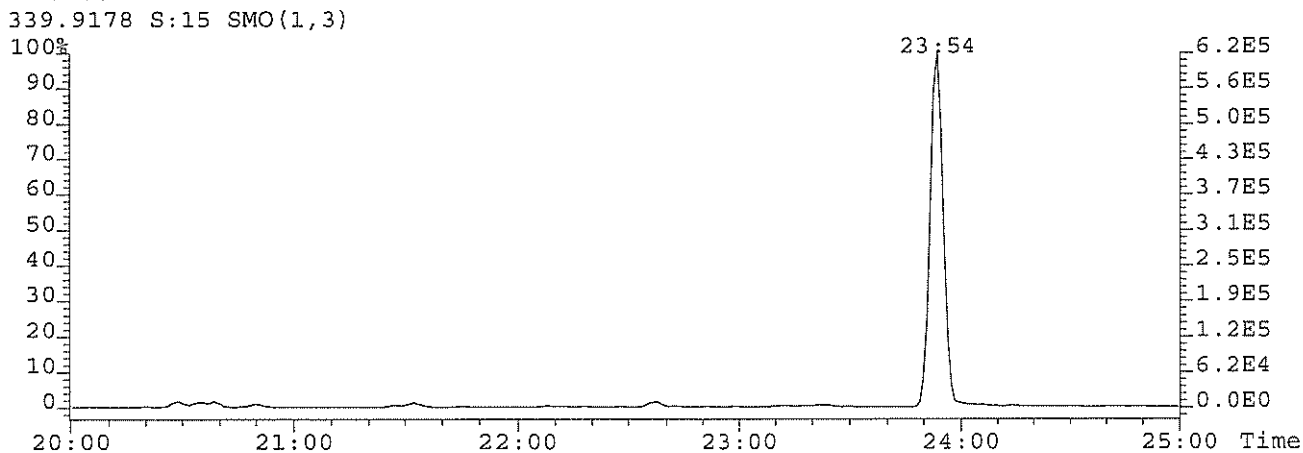
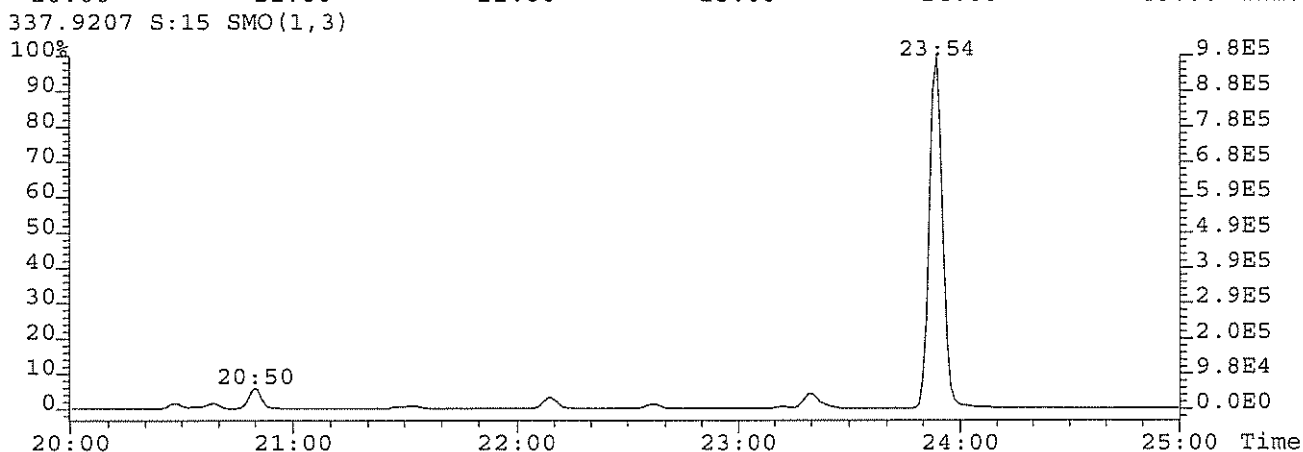
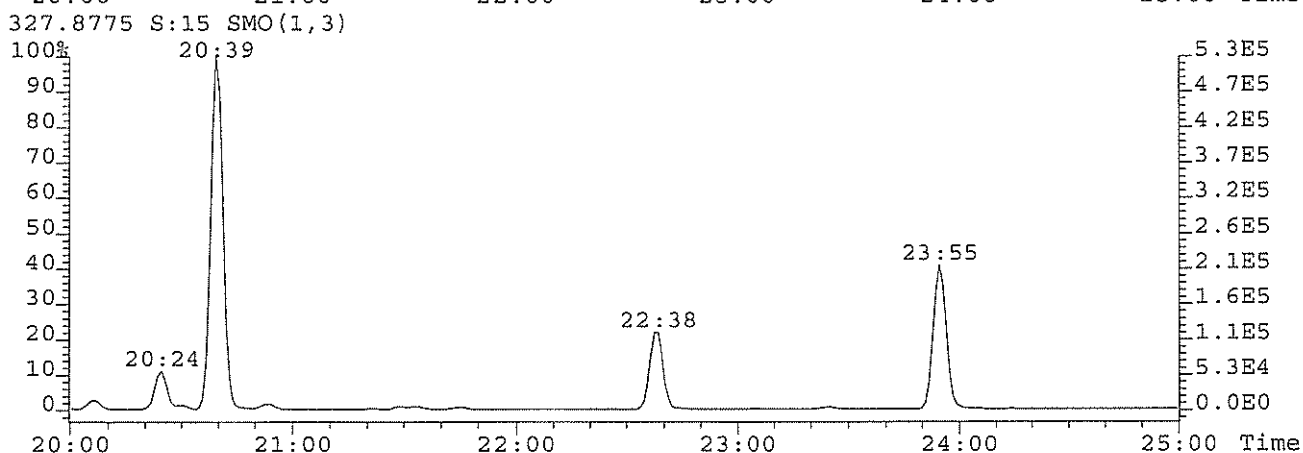
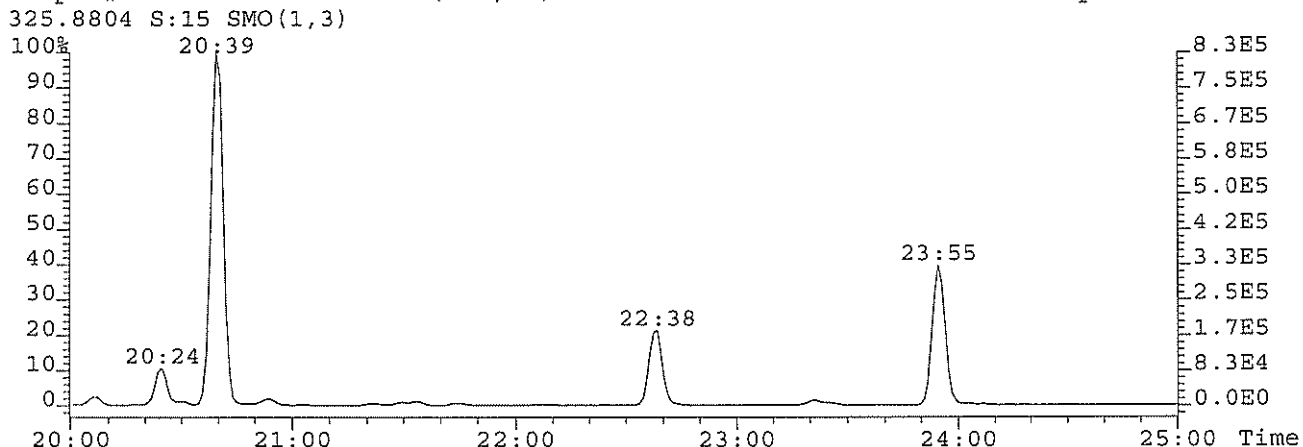
PCDDsクロマトグラム (12)  
(OCDD)

File:130713 #1-1430 Acq:13-JUL-2013 23:48:23 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0961 3 Exp:RH-PD22  
289.9224 S:15 SMO(1,3)



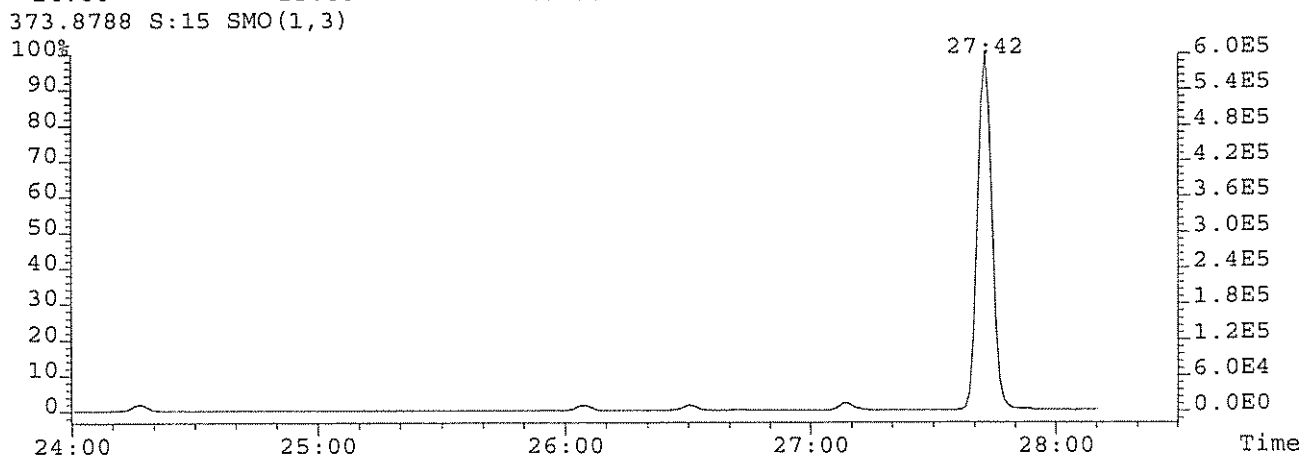
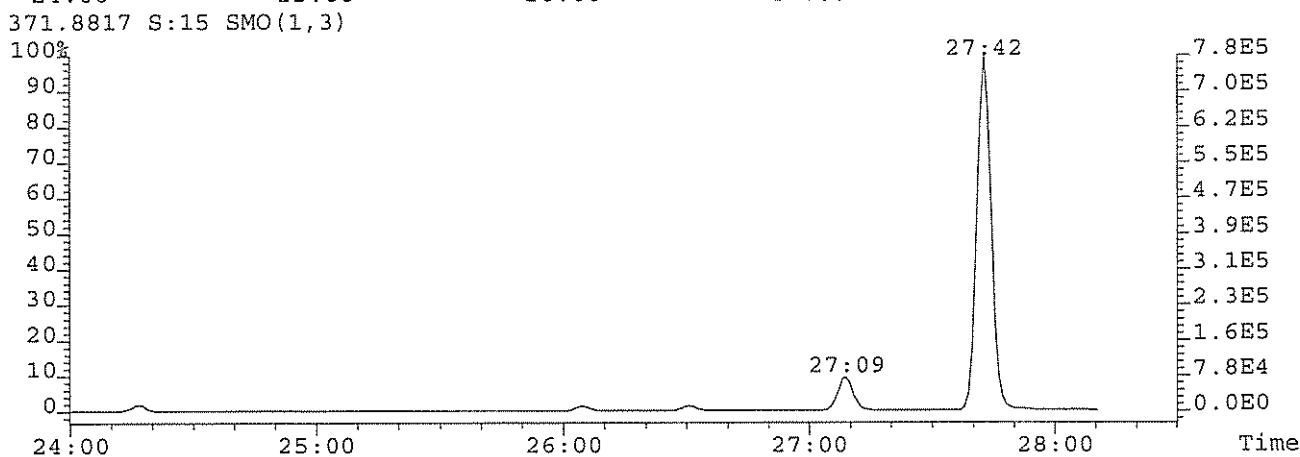
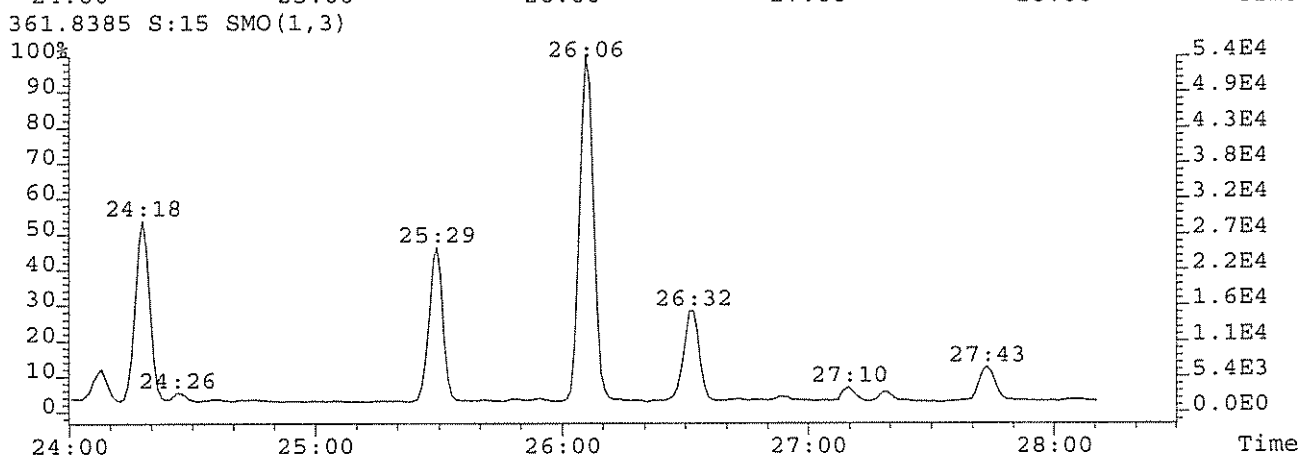
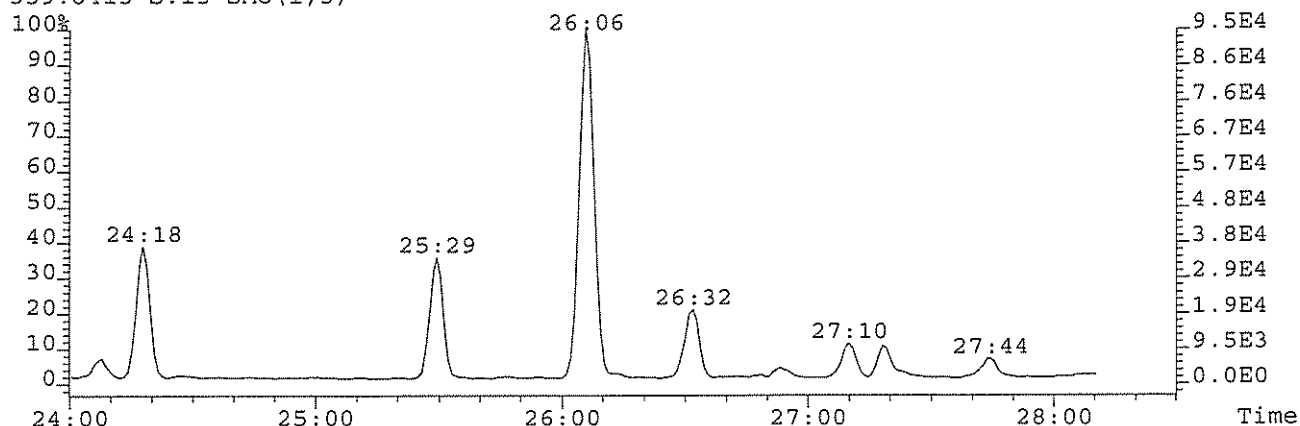
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130713 #1-1430 Acq:13-JUL-2013 23:48:23 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0961 3 Exp:RH-PD22



DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

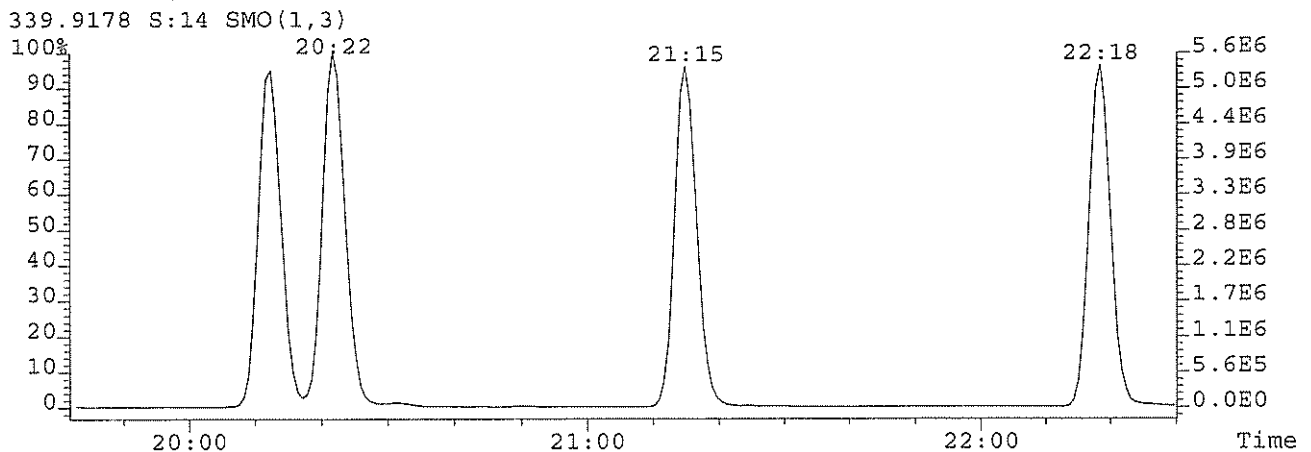
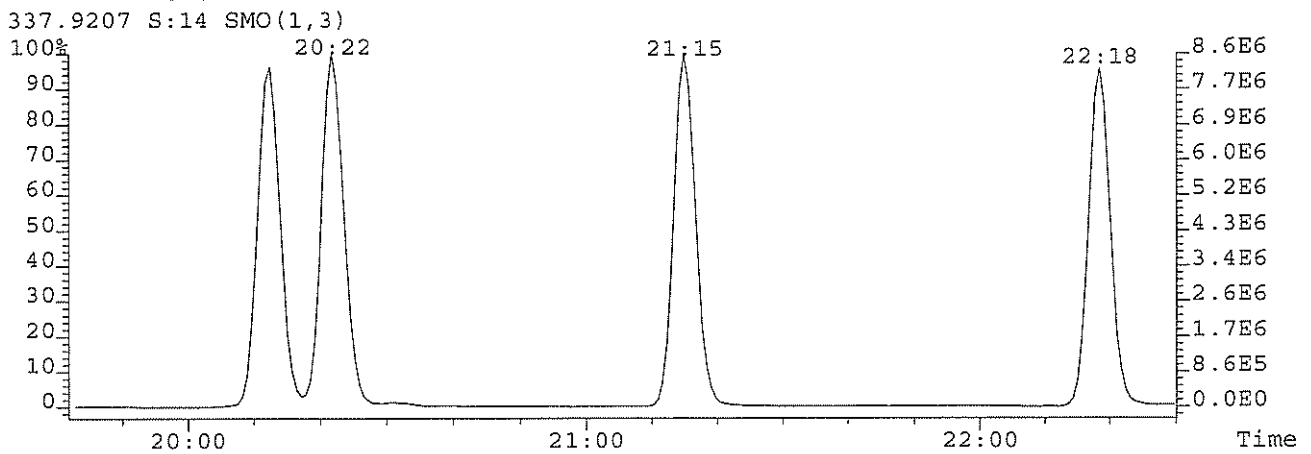
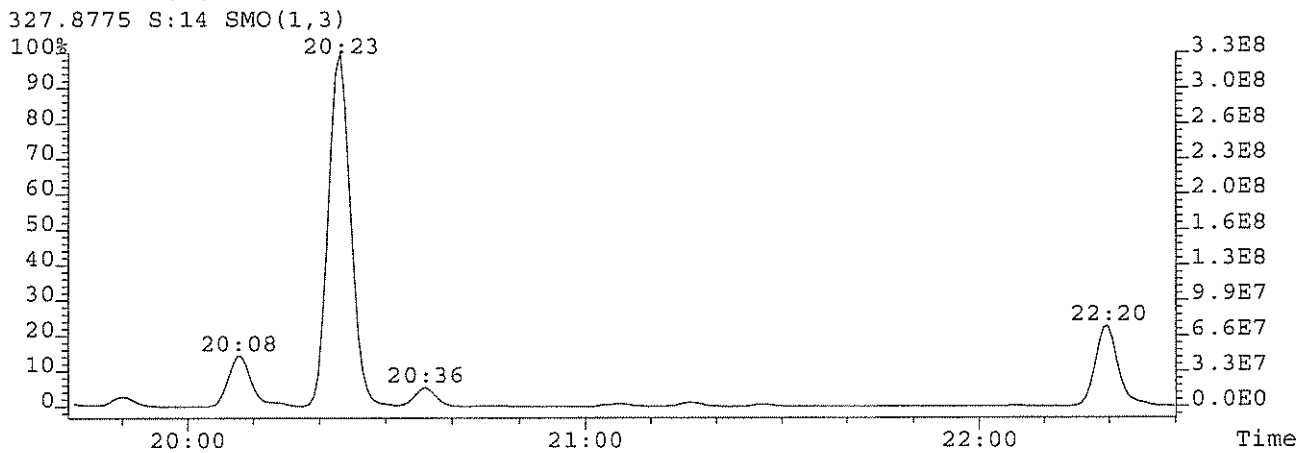
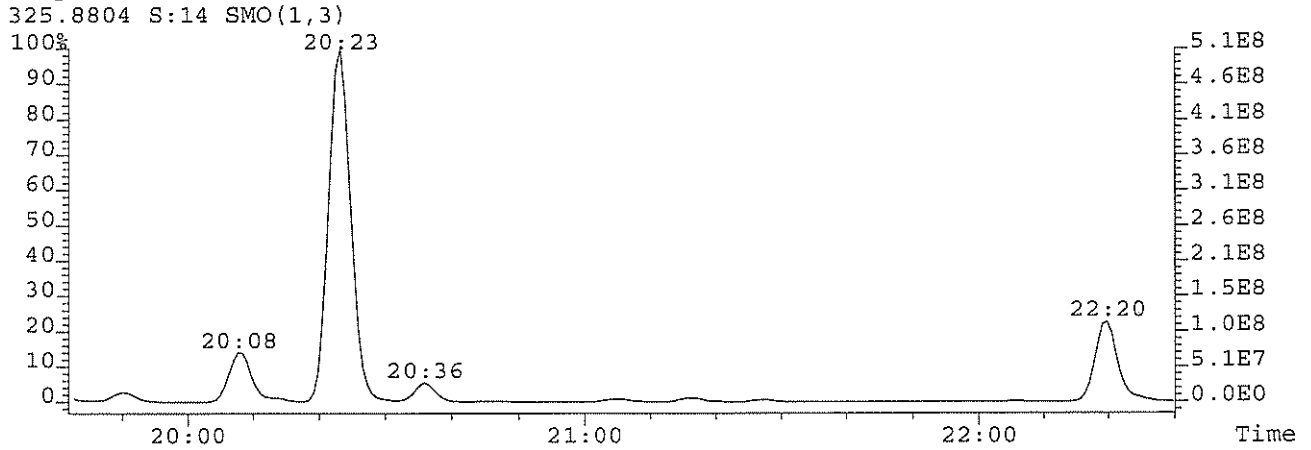
File:130713 #1-1430 Acq:13-JUL-2013 23:48:23 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#15 File Text:RH-12ms(5-8,nP) Text:XE13 0961 3 Exp:RH-PD22  
359.8415 S:15 SMO(1,3)



DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

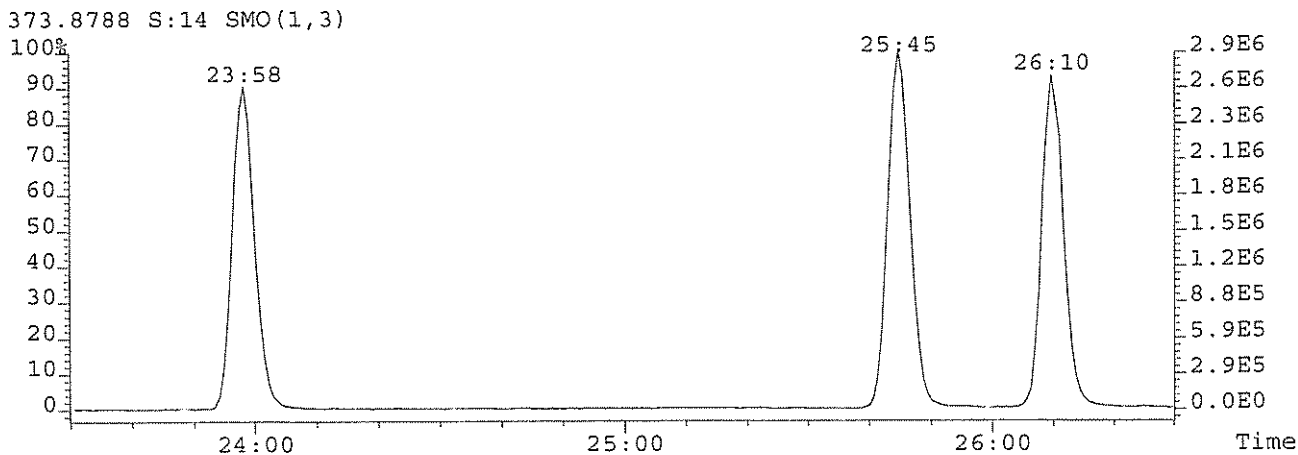
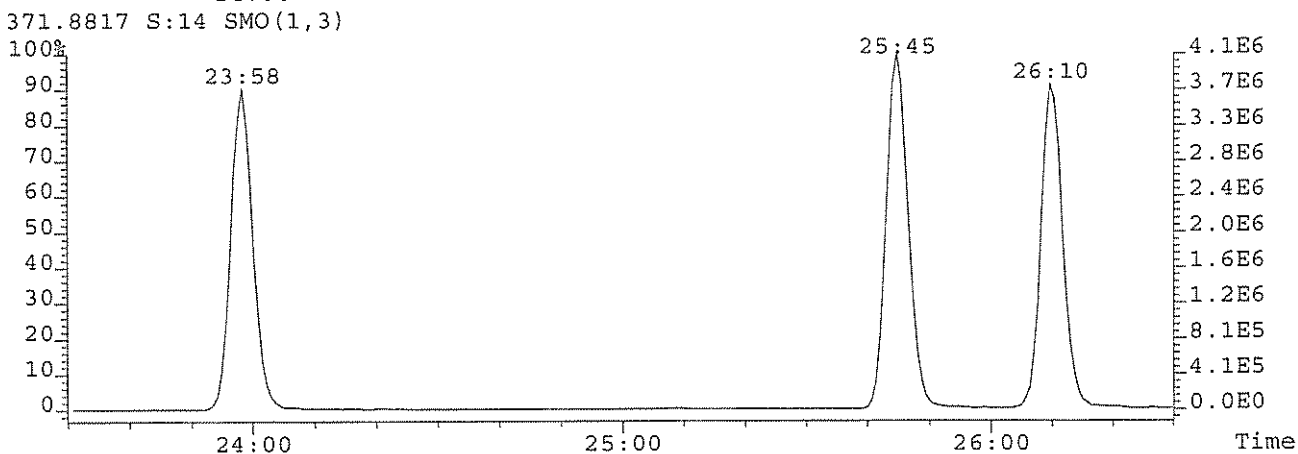
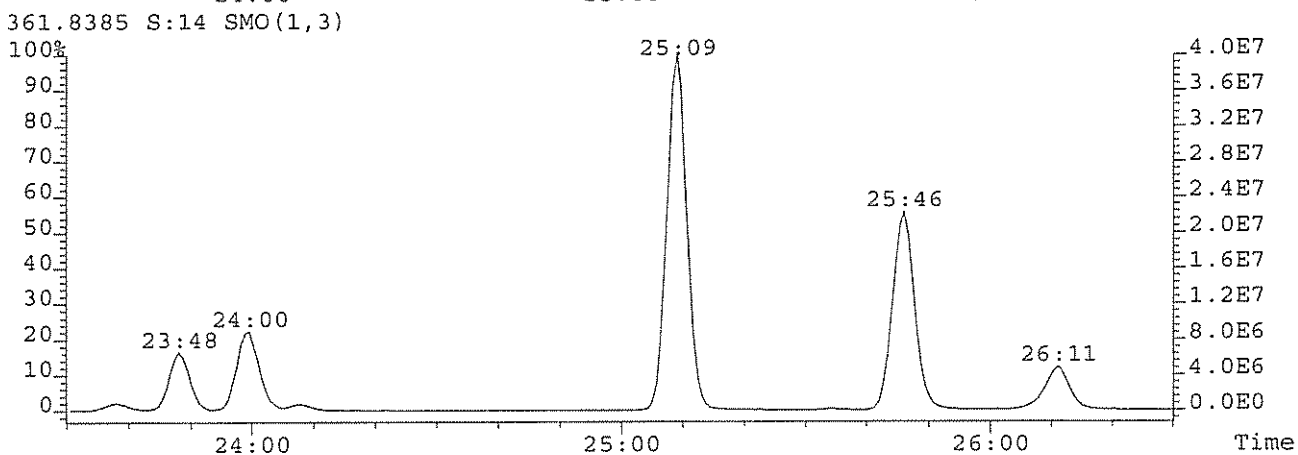
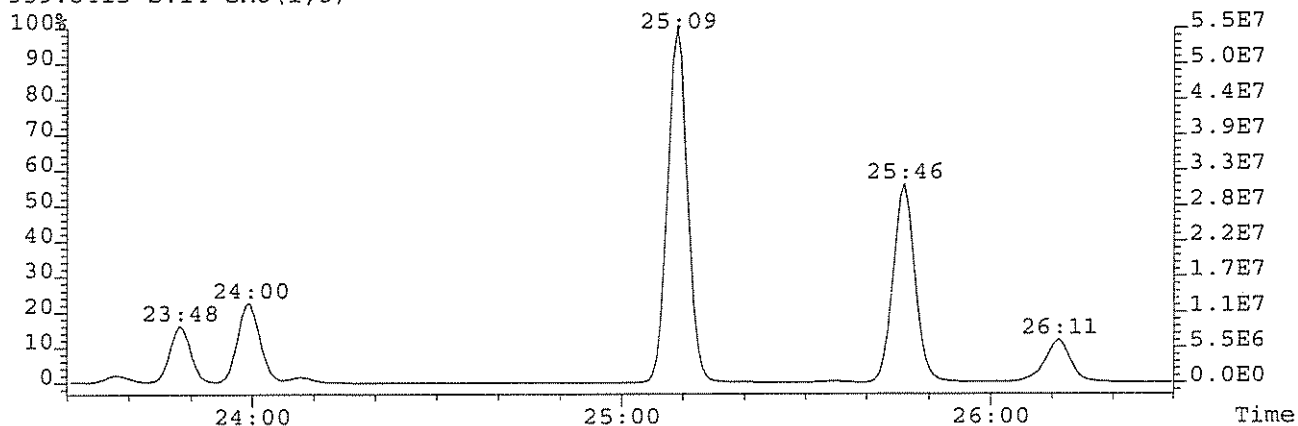


File:130713 #1-2899 Acq:13-JUL-2013 21:00:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:RH-12ms(mP) Text:XE13 0961 2 Exp:RH-MP11



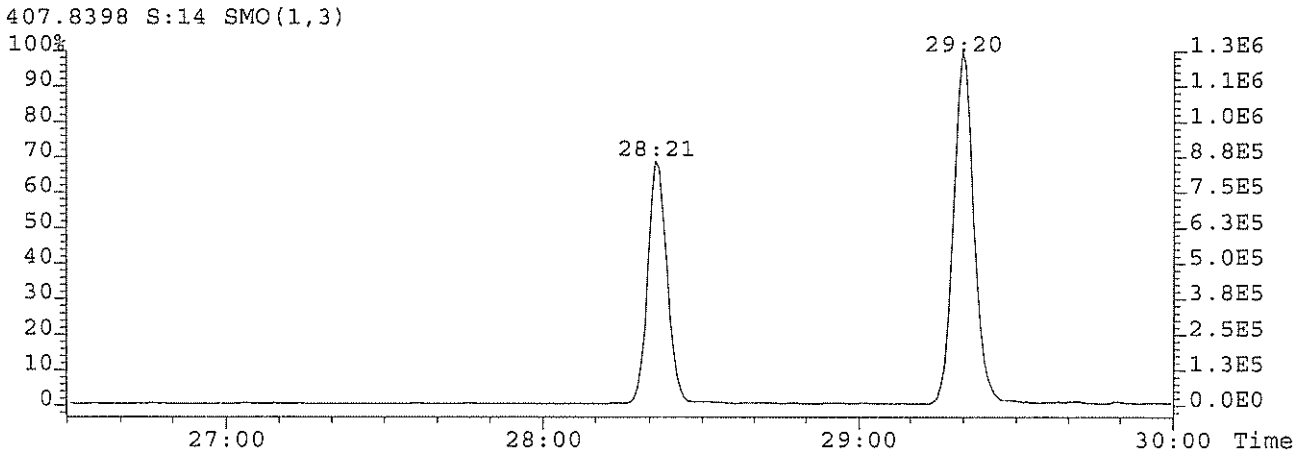
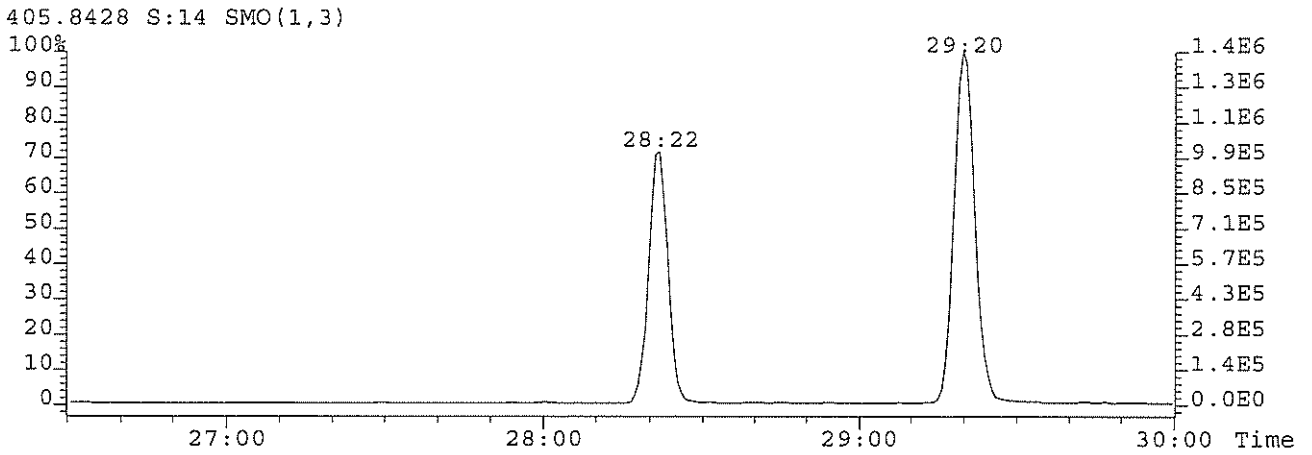
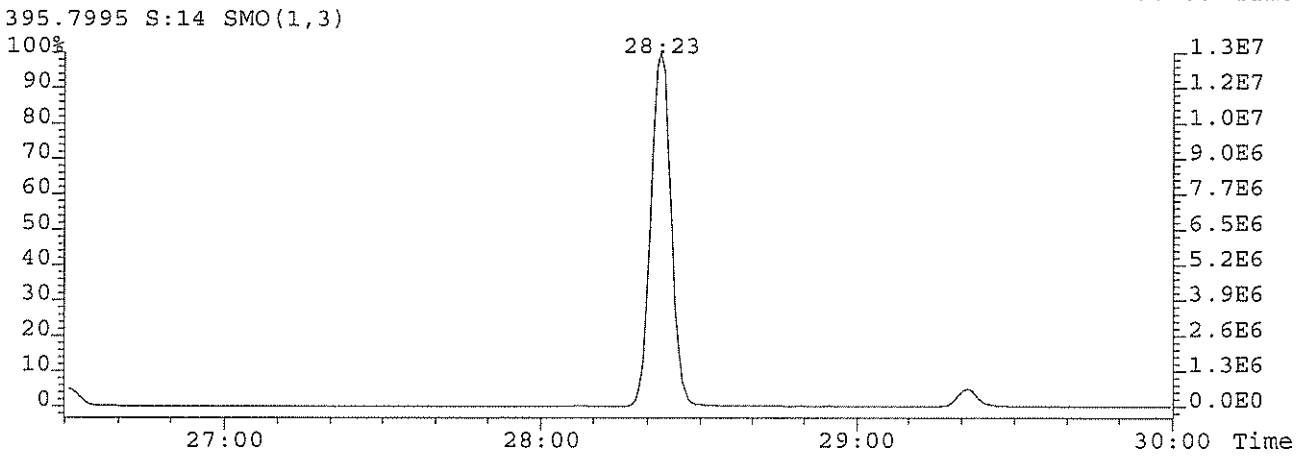
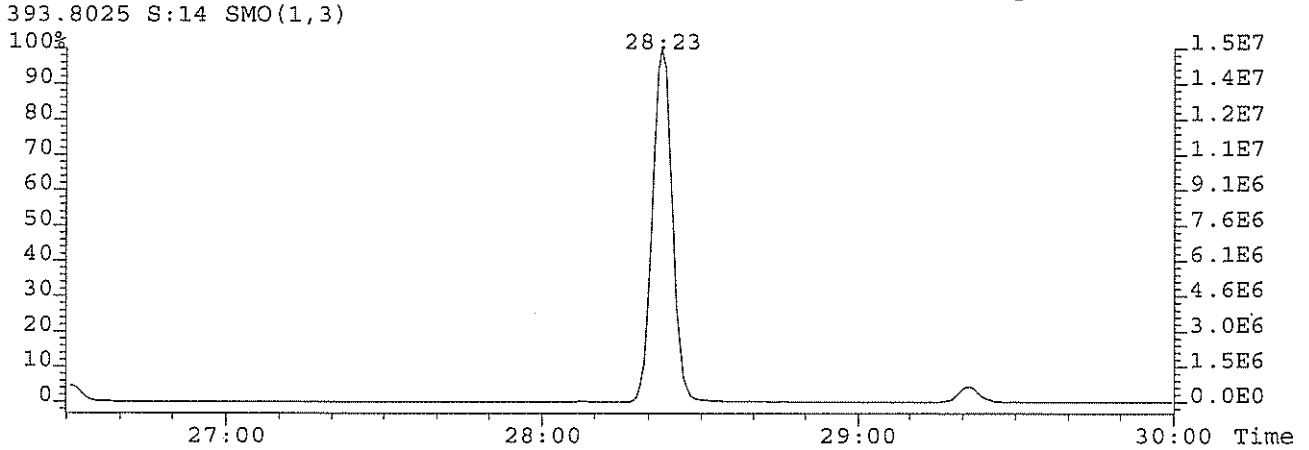
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130713 #1-2899 Acq:13-JUL-2013 21:00:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:RH-12ms(mP) Text:XE13 0961 2 Exp:RH-MP11  
359.8415 S:14 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130713 #1-2899 Acq:13-JUL-2013 21:00:58 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#14 File Text:RH-12ms(mP) Text:XE13 0961 2 Exp:RH-MP11

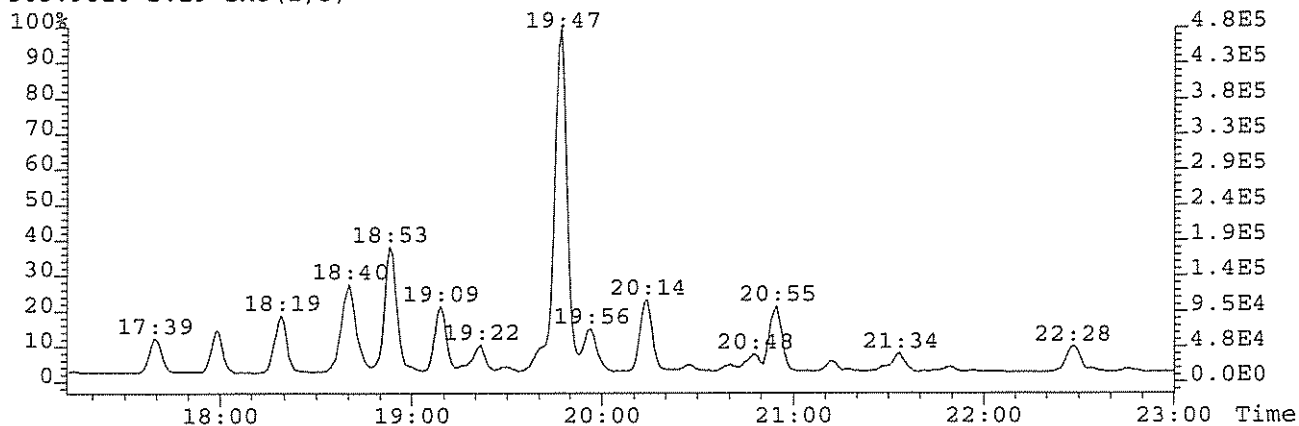


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

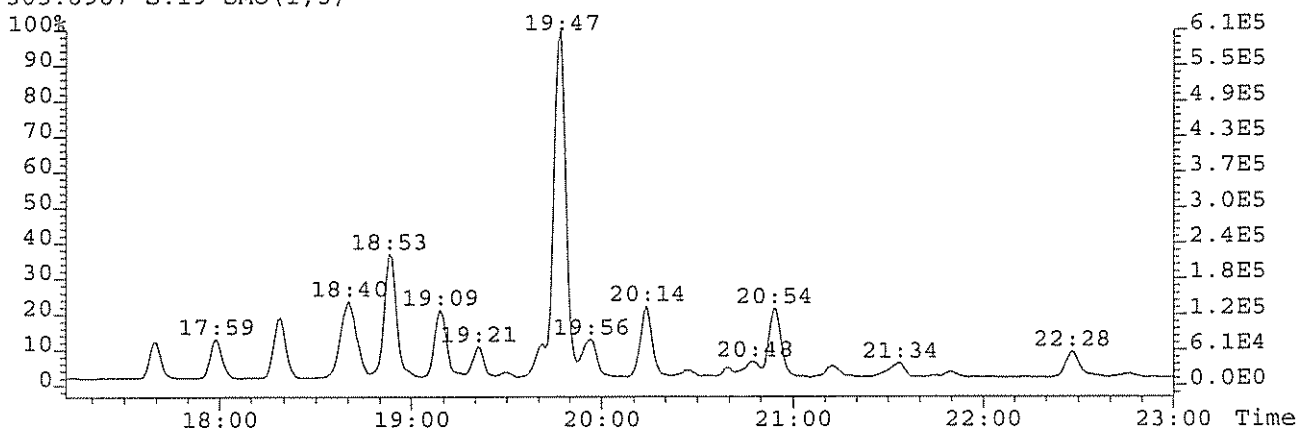
試料管理番号	XE 130962
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.16

File:130712-2 #1-1578 Acq:13-JUL-2013 06:34:08 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:BPX-DXN(4-6DXN) Text:XE13 0962 Exp:BPX04

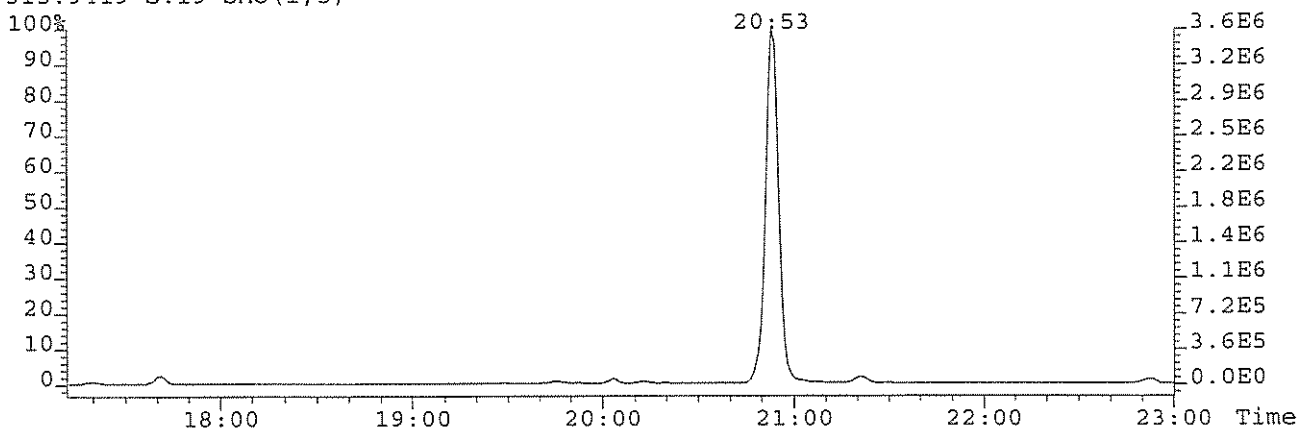
303.9016 S:19 SMO(1,3)



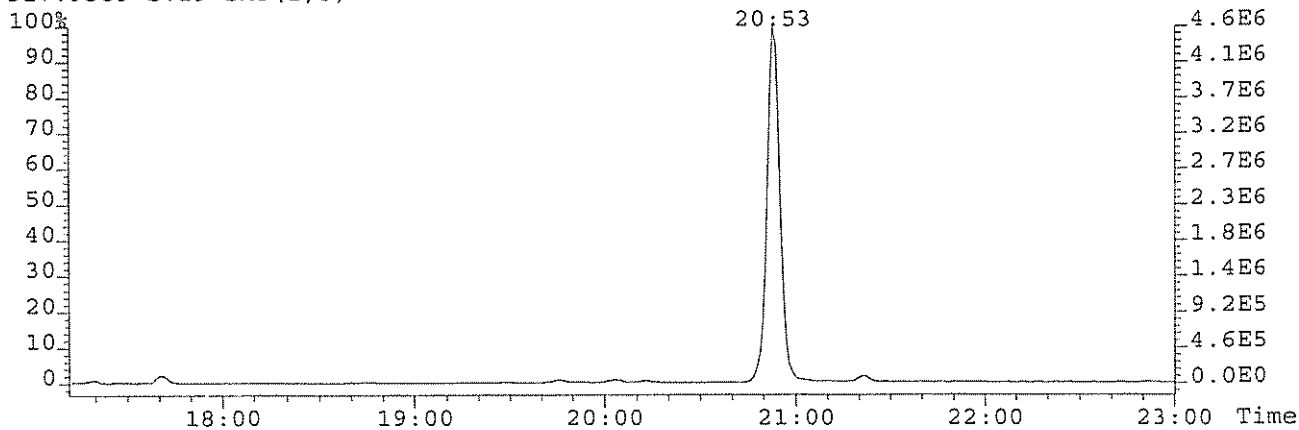
305.8987 S:19 SMO(1,3)



315.9419 S:19 SMO(1,3)

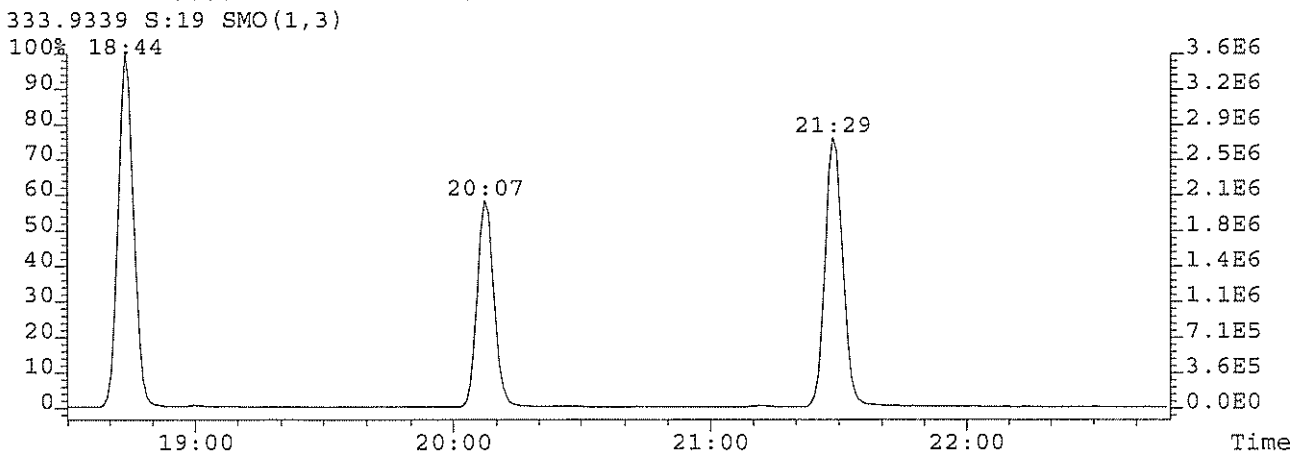
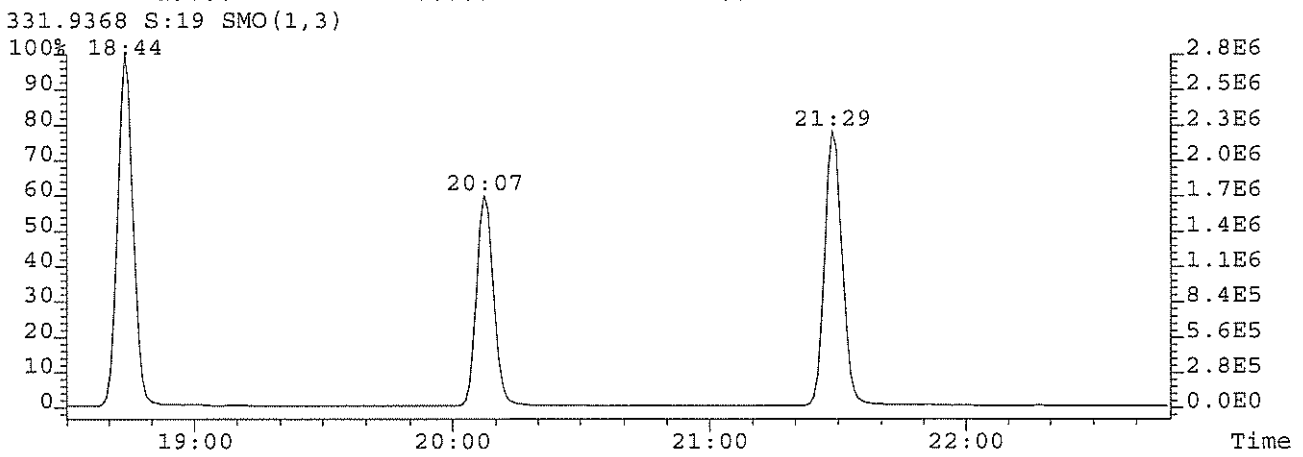
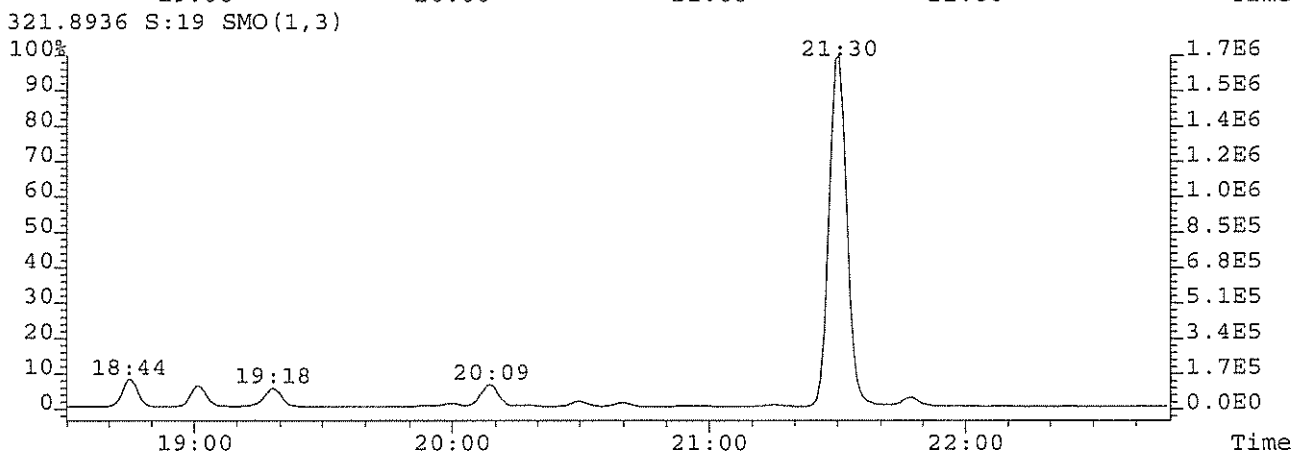
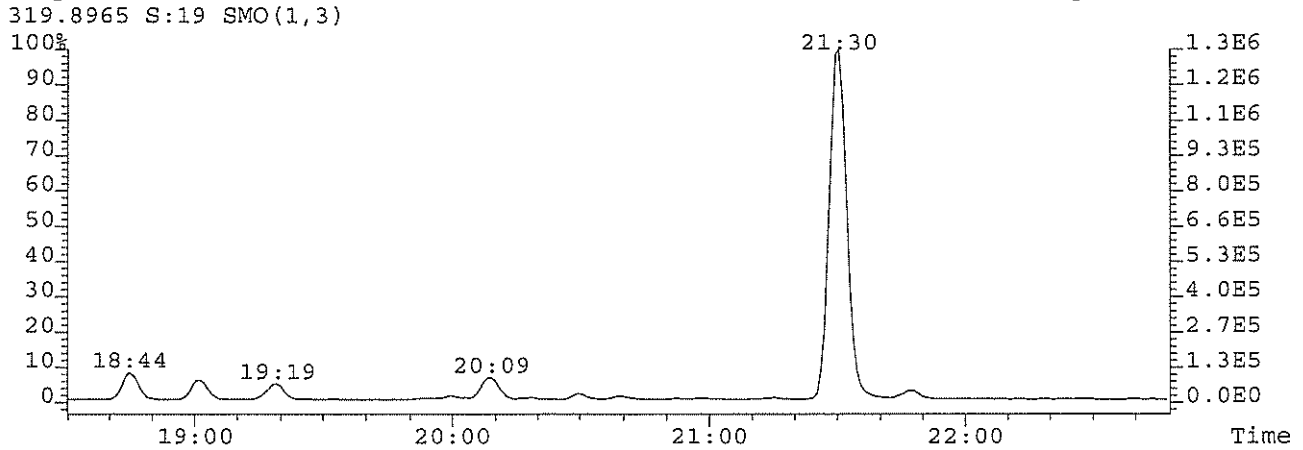


317.9389 S:19 SMO(1,3)



PCDFsクロマトグラム (1)  
(TeCDFs)

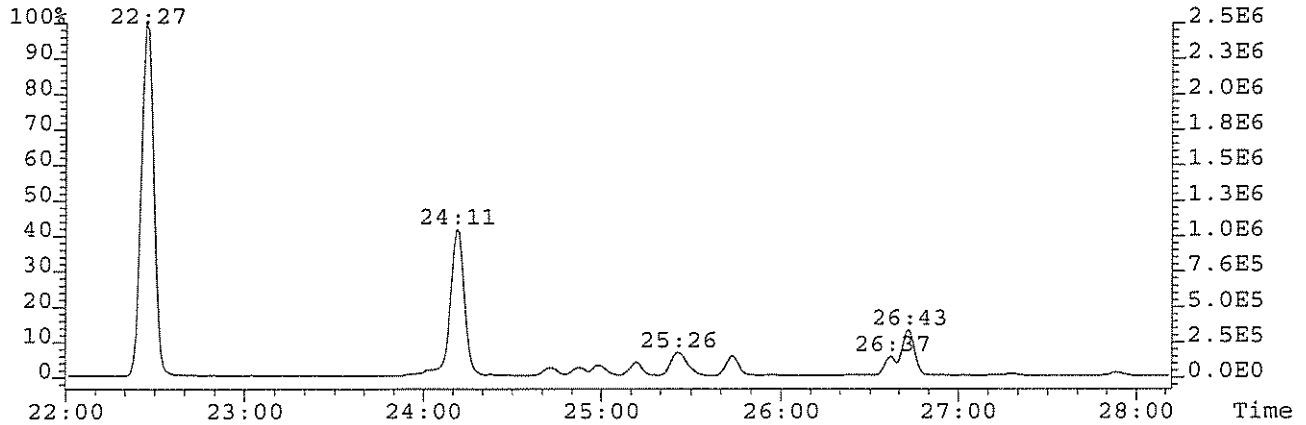
File:130712-2 #1-1578 Acq:13-JUL-2013 06:34:08 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:BPX-DXN(4-6DXN) Text:XE13 0962 Exp:BPX04



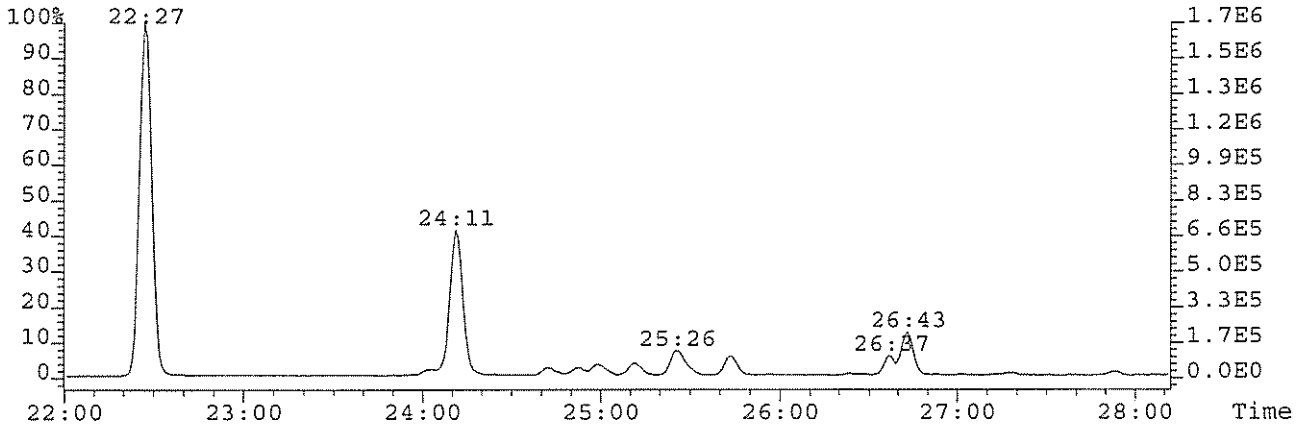
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130712-2 #1-1578 Acq:13-JUL-2013 06:34:08 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:BPX-DXN(4-6DXN) Text:XE13 0962 Exp:BPX04

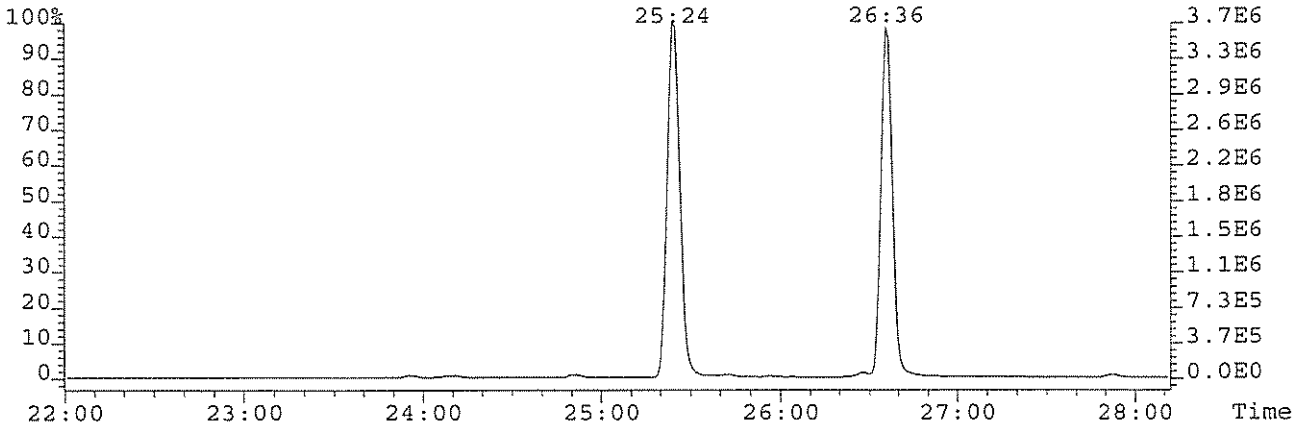
339.8597 S:19 SMO(1,3)



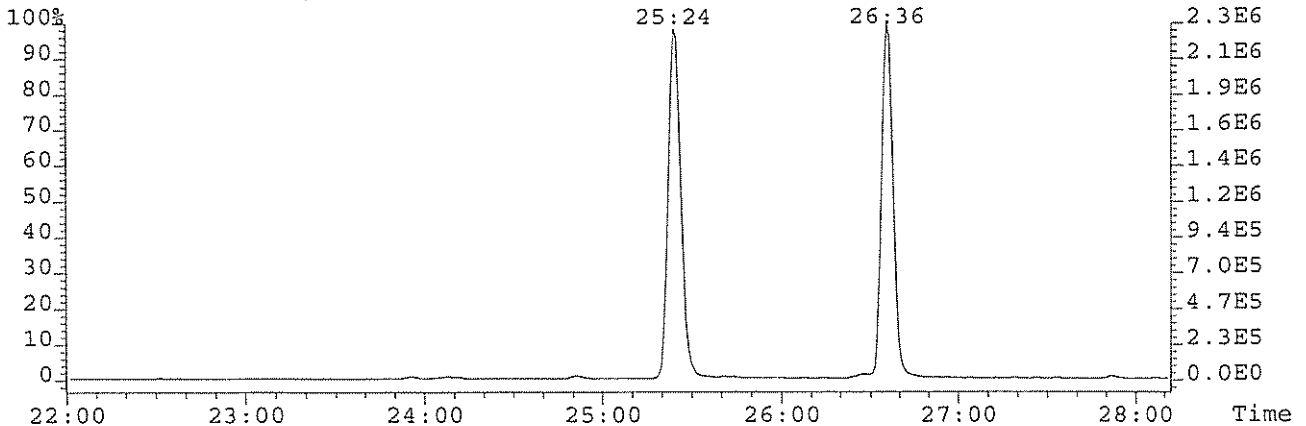
341.8568 S:19 SMO(1,3)



351.9000 S:19 SMO(1,3)



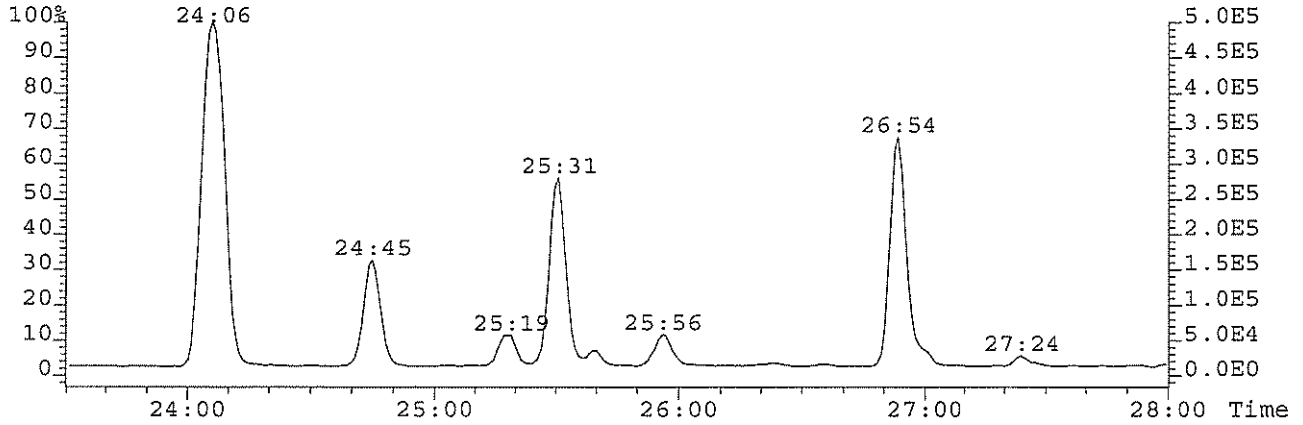
353.8970 S:19 SMO(1,3)



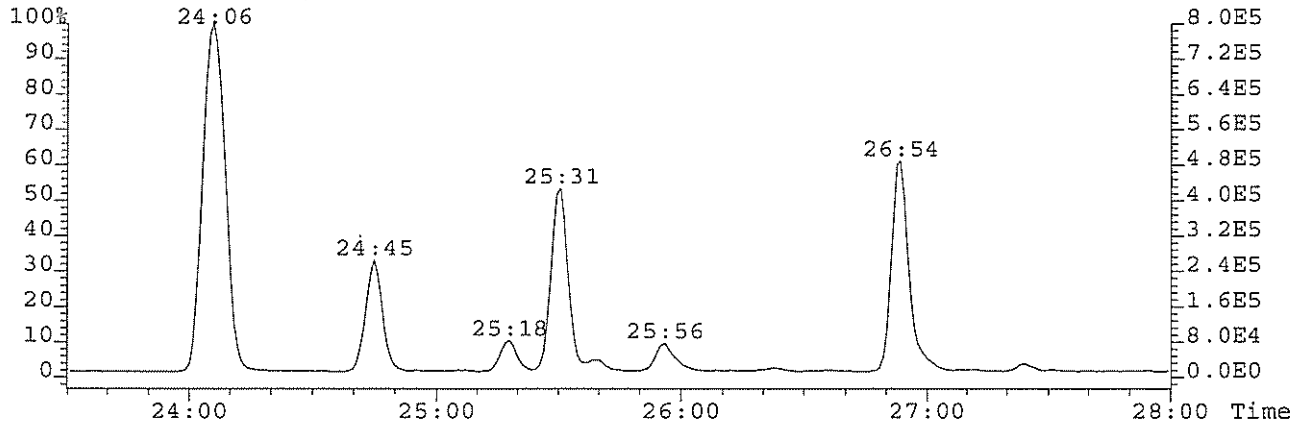
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 06:34:08 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:BPX-DXN(4-6DXN) Text:XE13 0962 Exp:BPX04

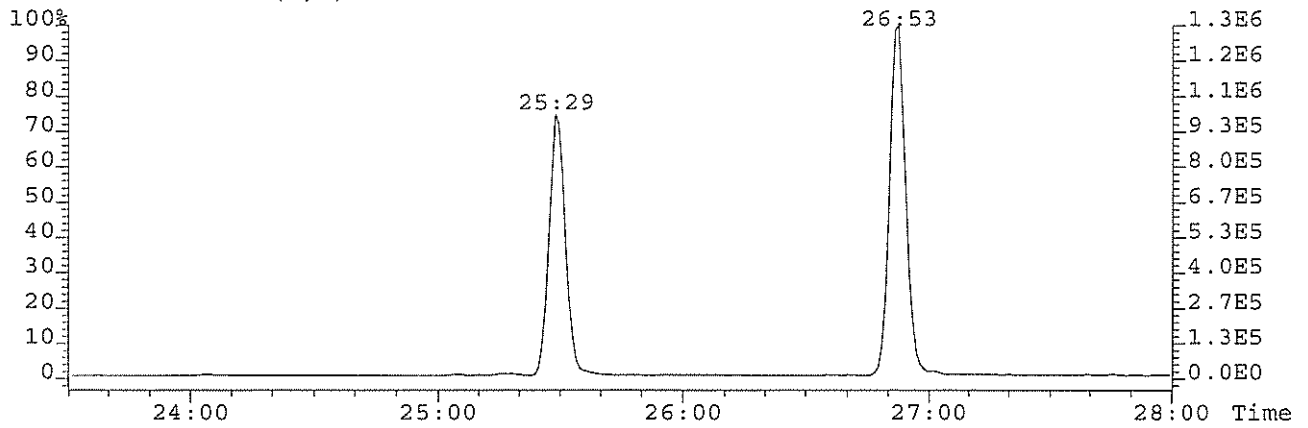
353.8576 S:19 SMO(1,3)



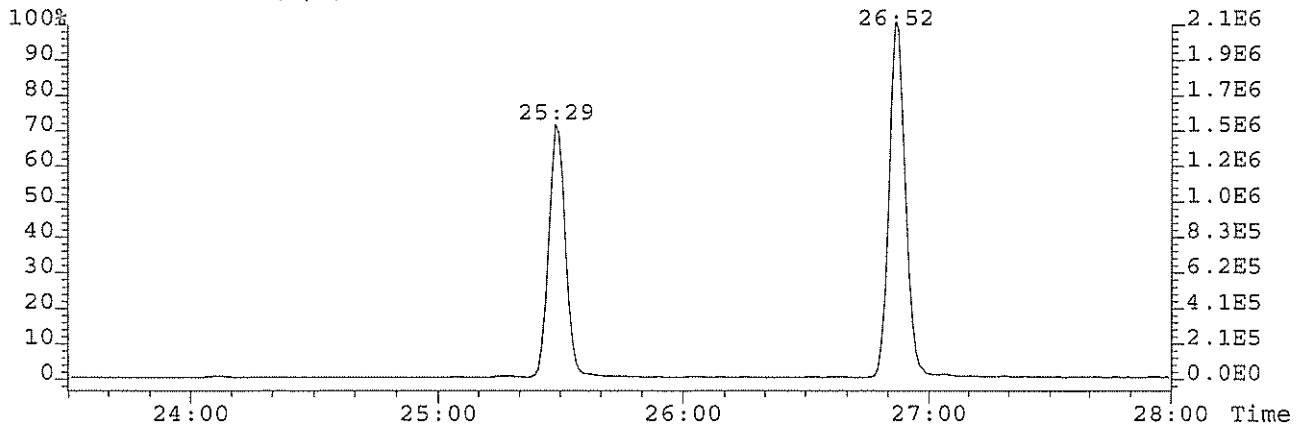
355.8546 S:19 SMO(1,3)



365.8978 S:19 SMO(1,3)



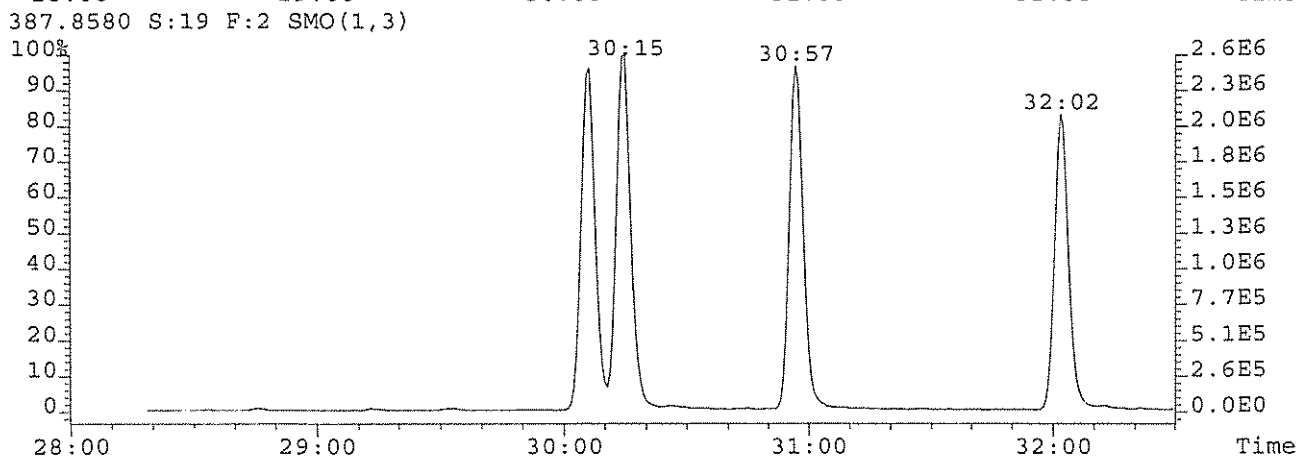
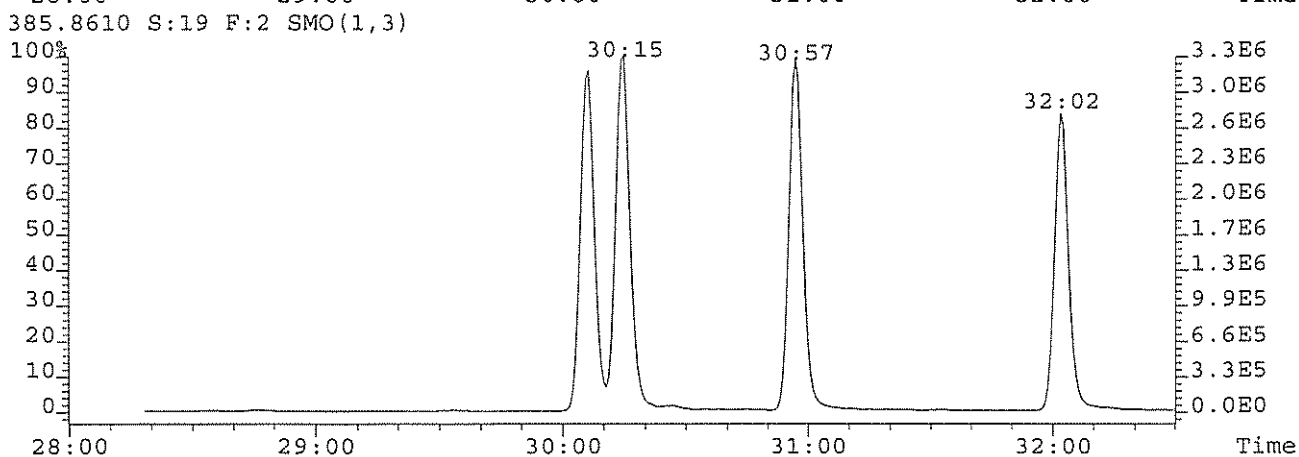
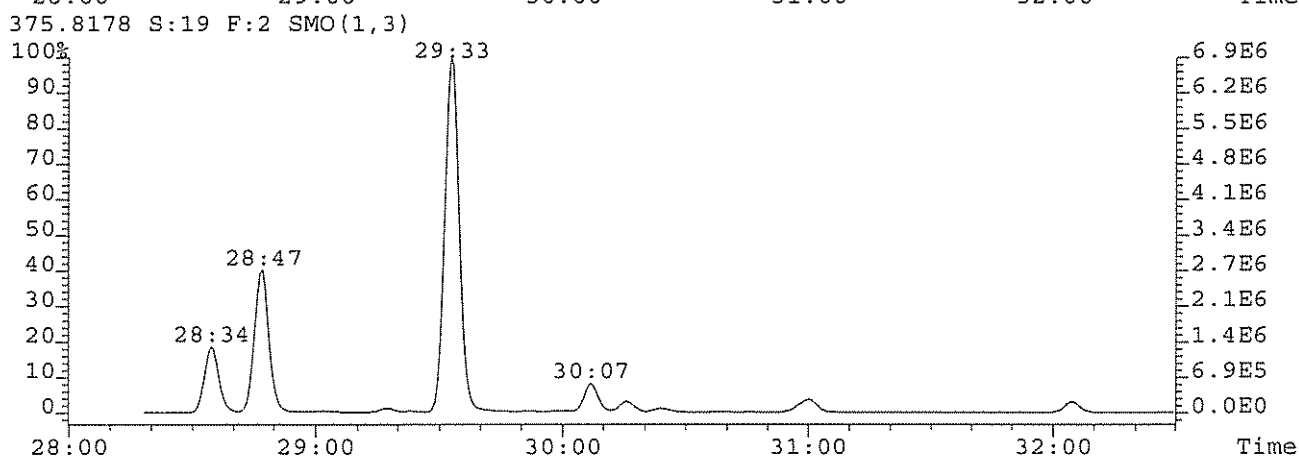
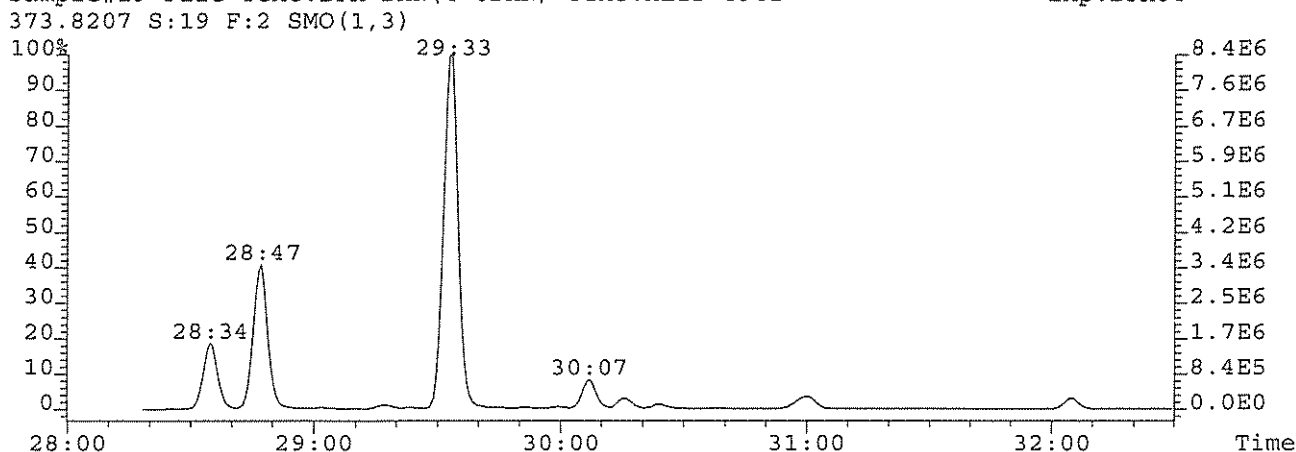
367.8949 S:19 SMO(1,3)



PCDDsクロマトグラム (4)  
(PeCDDs)



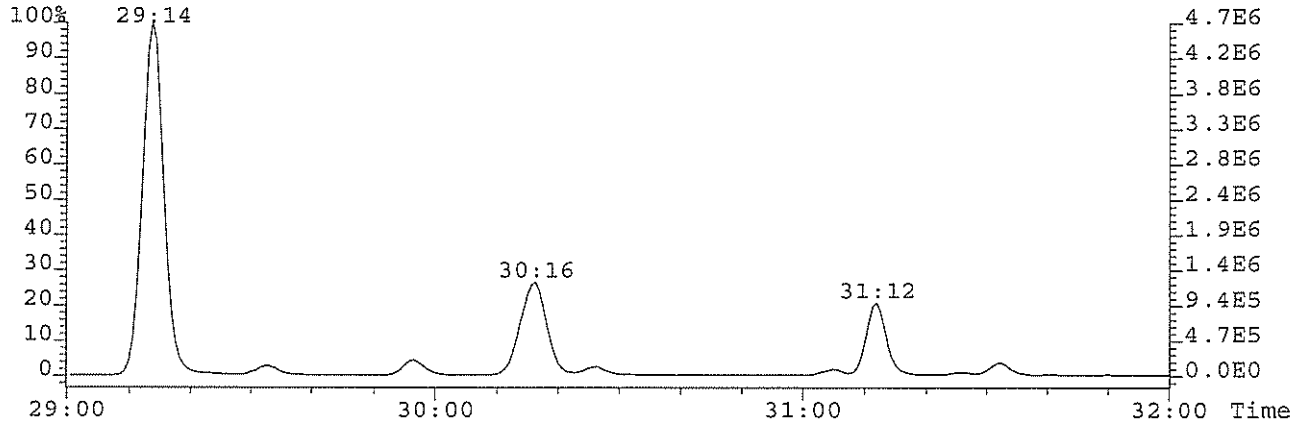
File:130712-2 #1-1116 Acq:13-JUL-2013 06:34:08 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:BPX-DXN(4-6DXN) Text:XE13 0962 Exp:BPX04



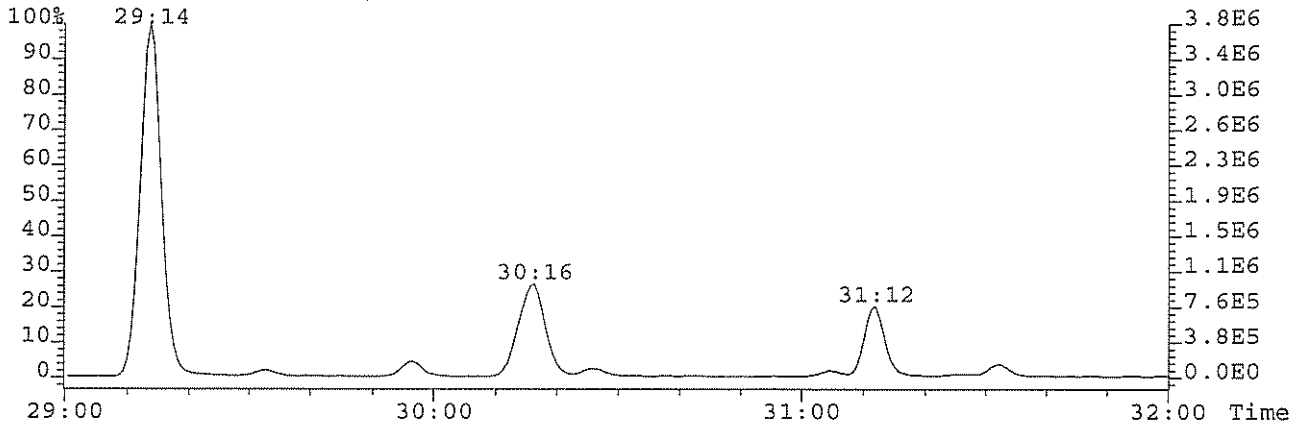
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1116 Acq:13-JUL-2013 06:34:08 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:BPX-DXN(4-6DXN) Text:XE13 0962 Exp:BPX04

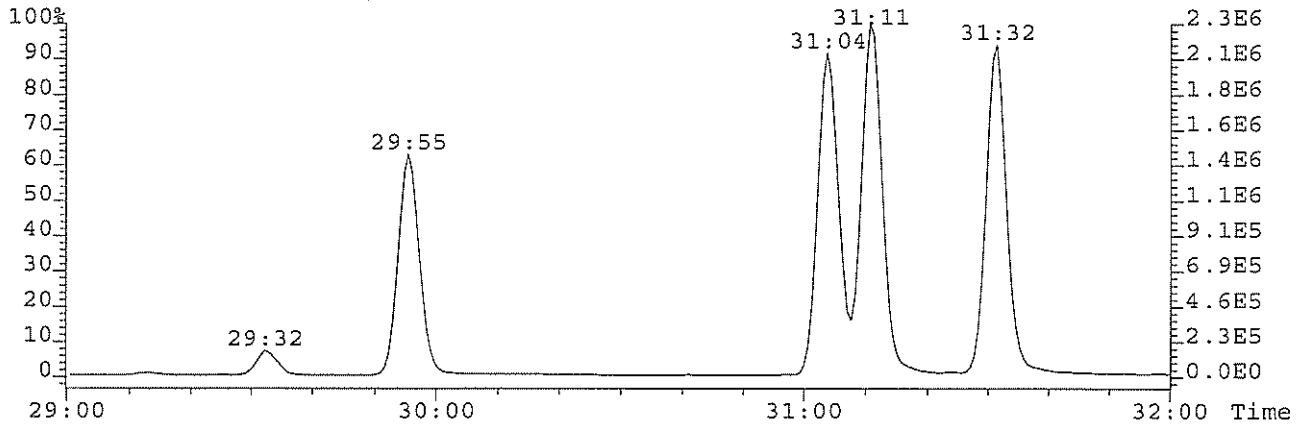
389.8156 S:19 F:2 SMO(1,3)



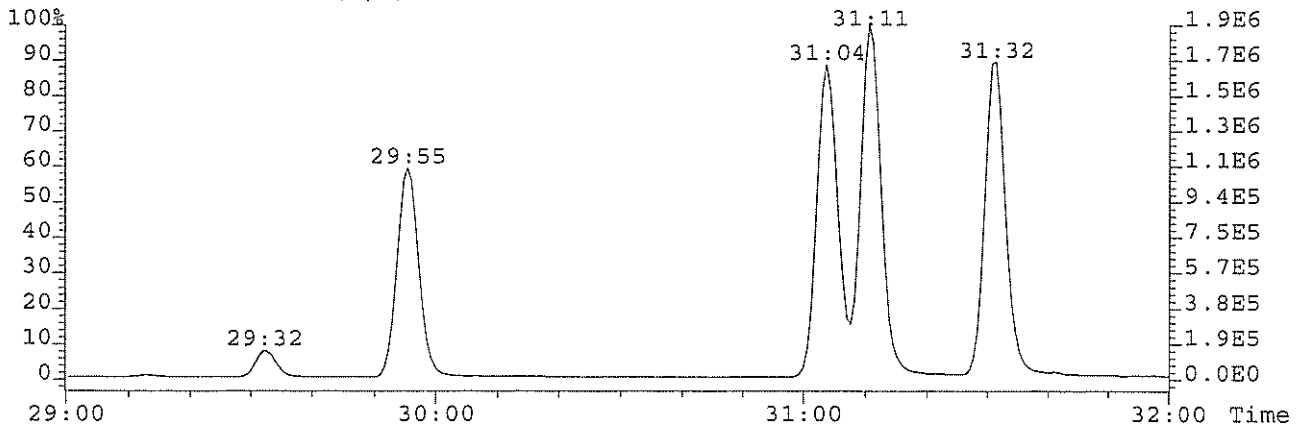
391.8127 S:19 F:2 SMO(1,3)



401.8559 S:19 F:2 SMO(1,3)

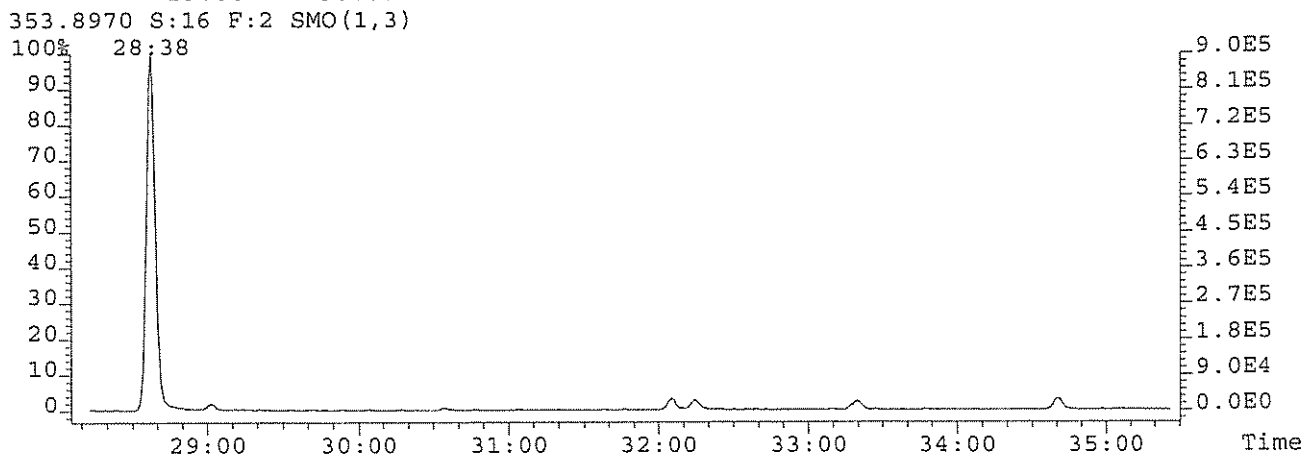
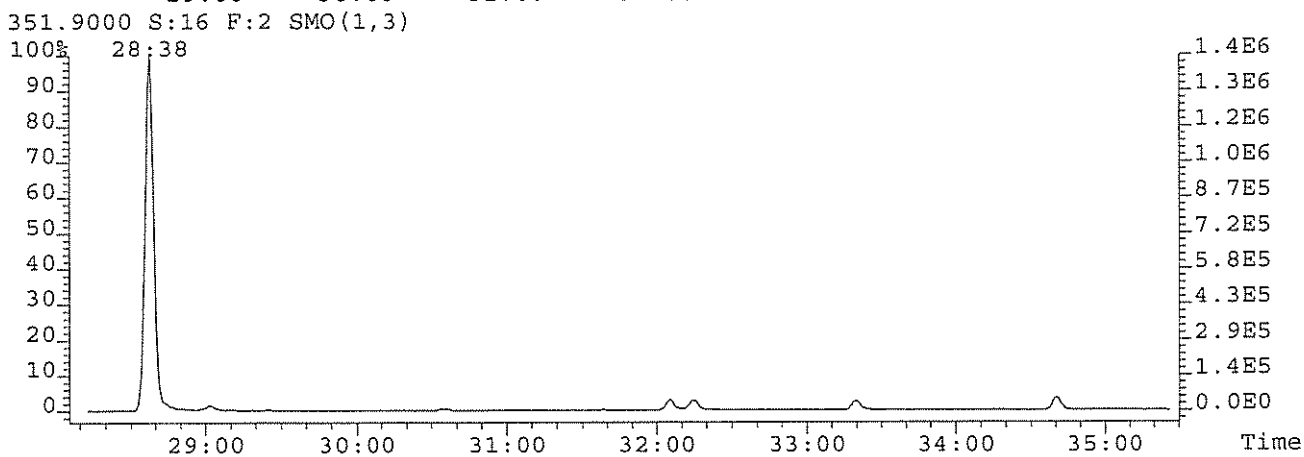
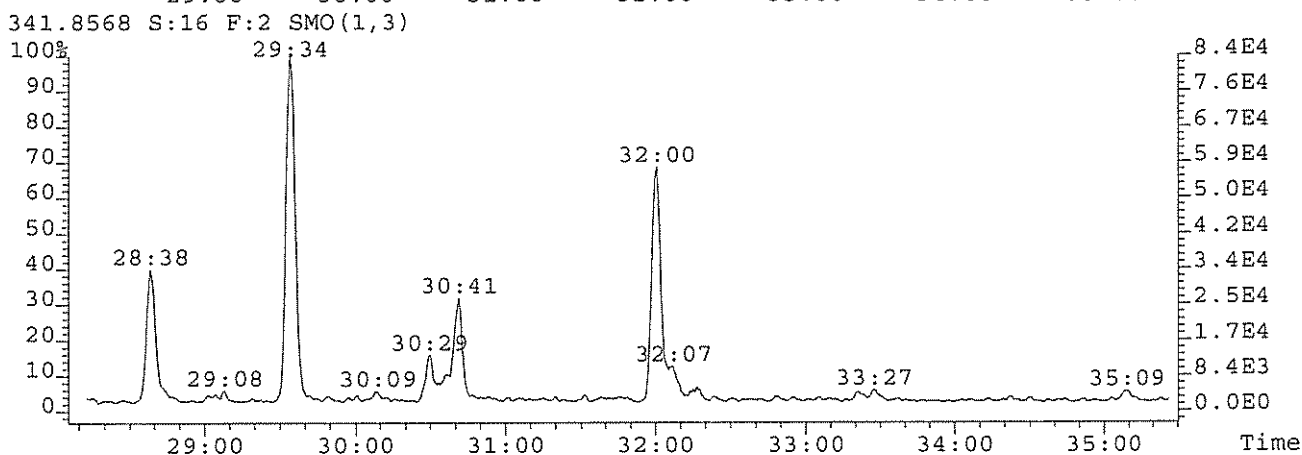
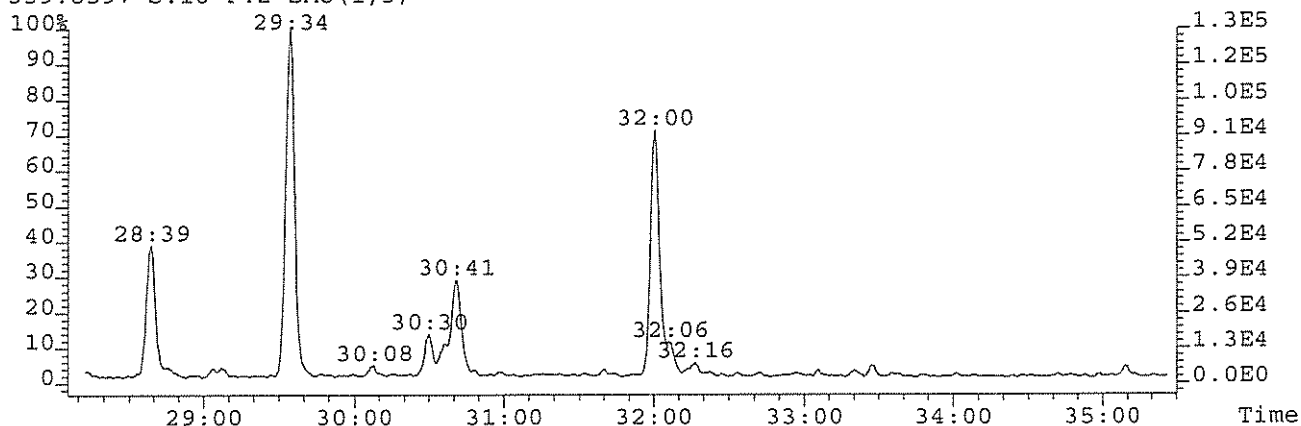


403.8530 S:19 F:2 SMO(1,3)



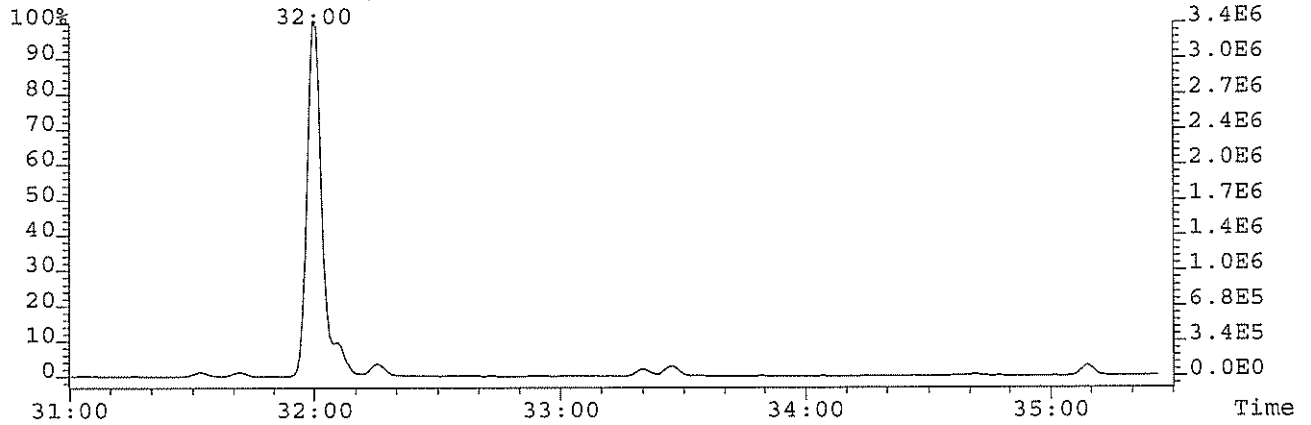
PCDDsクロマトグラム (6)  
(HxCDDs)

File:130713 #1-649 Acq:14-JUL-2013 00:37:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XEI3 0962 3 Exp:RH-PD22  
339.8597 S:16 F:2 SMO(1,3)

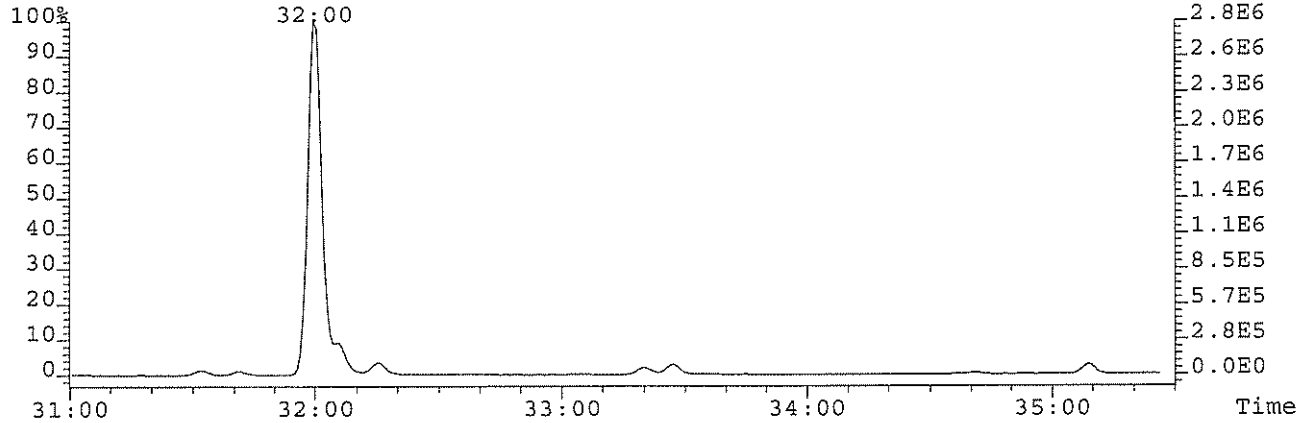


PeCDFsクロマトグラム (7)  
(23478-PeCDF)

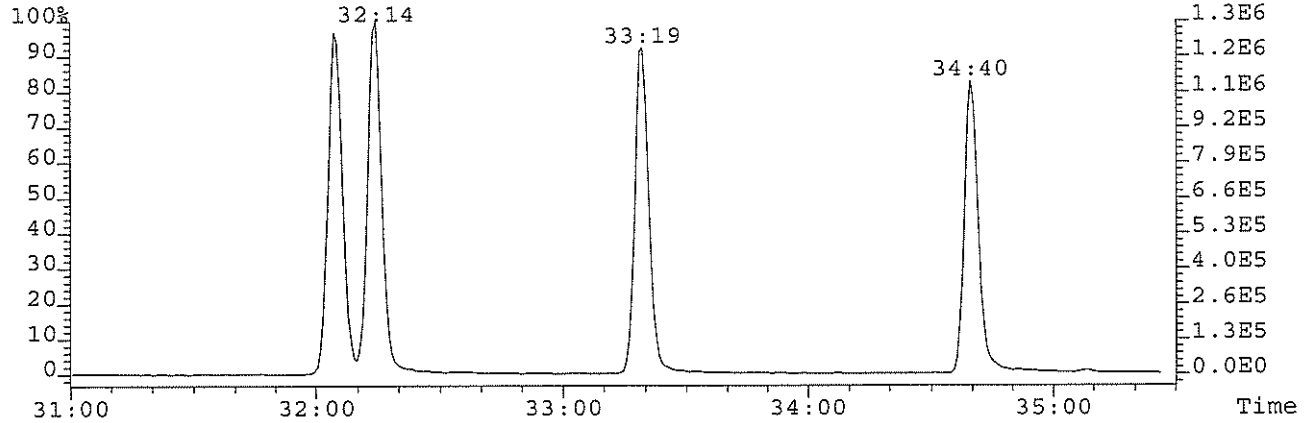
File:130713 #1-649 Acq:14-JUL-2013 00:37:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0962 3 Exp:RH-PD22  
373.8207 S:16 F:2 SMO(1,3)



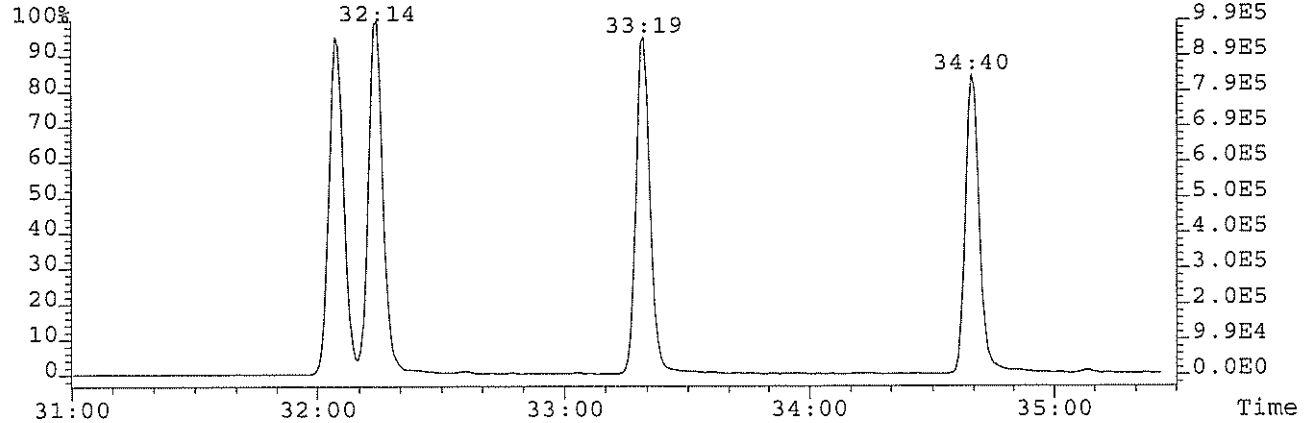
375.8178 S:16 F:2 SMO(1,3)



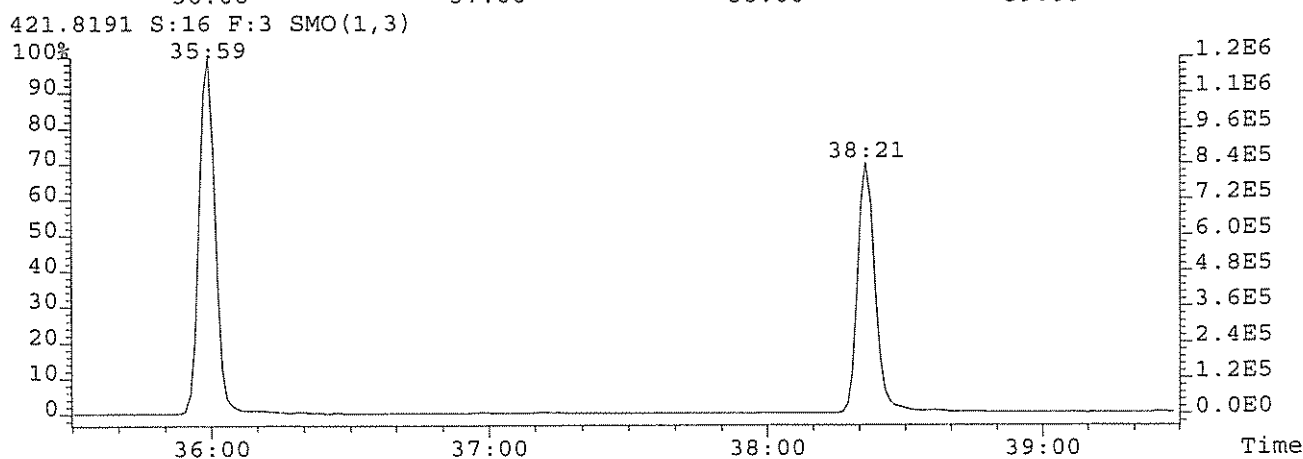
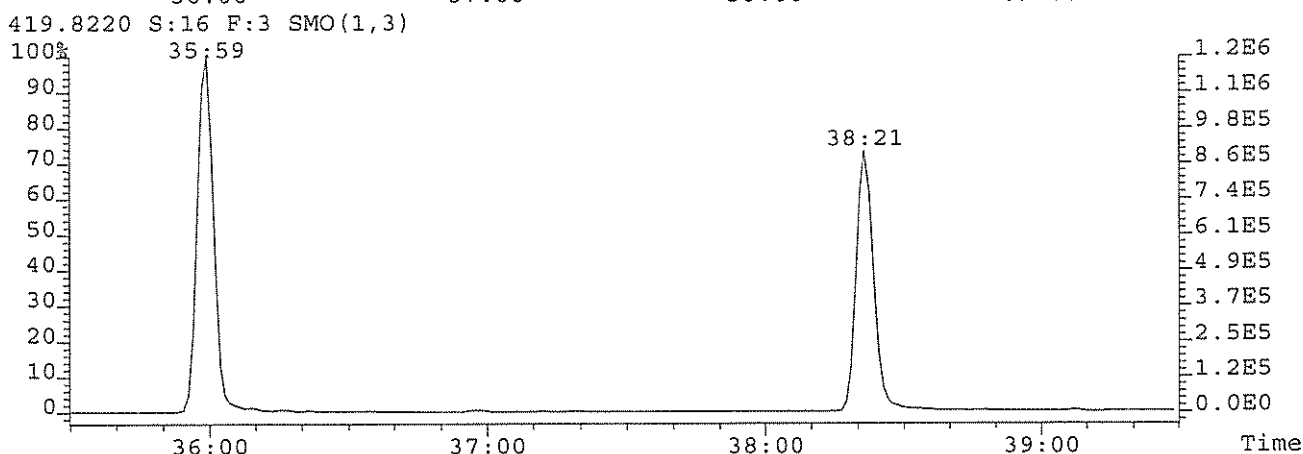
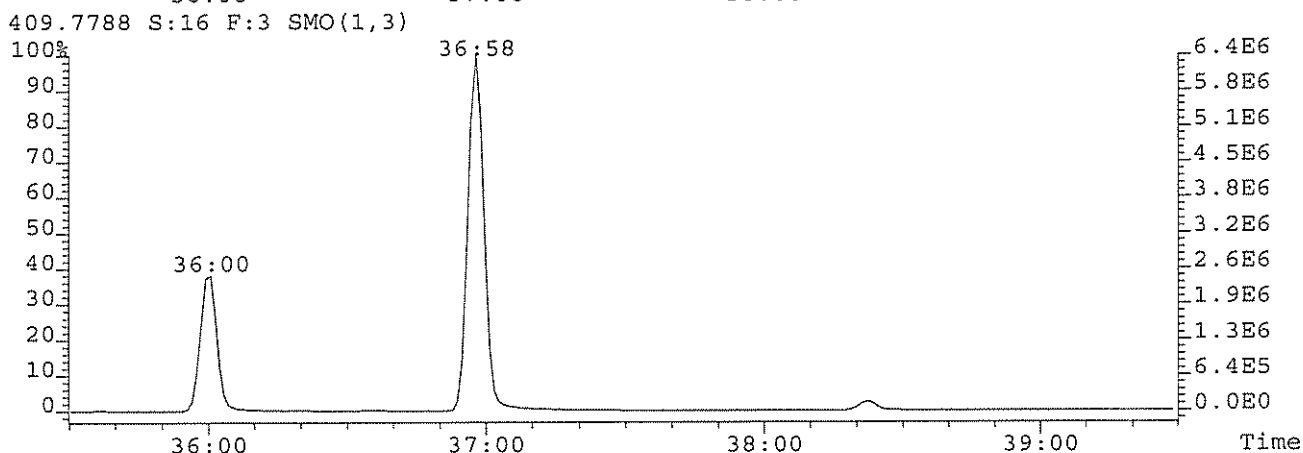
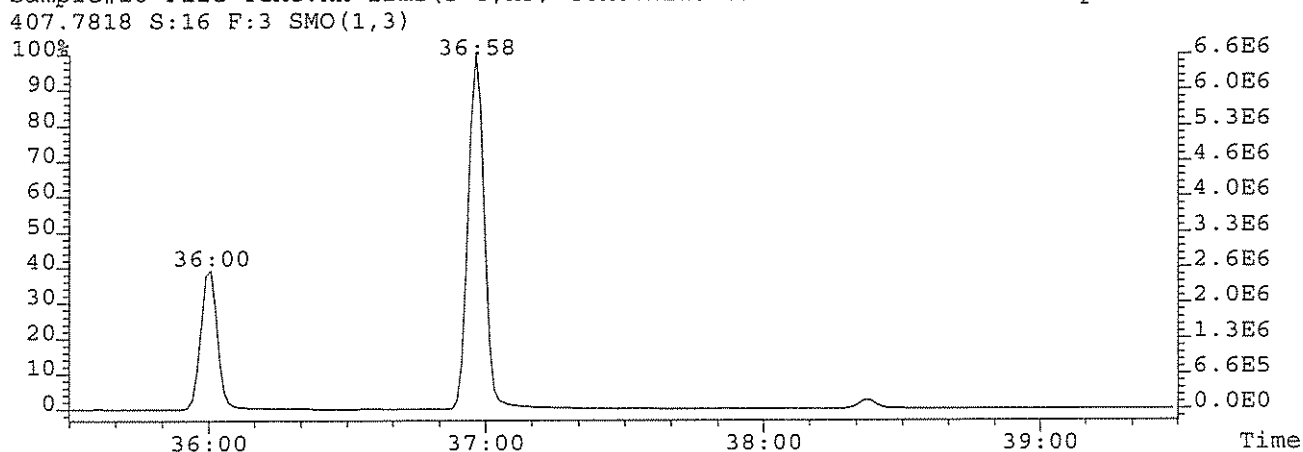
385.8610 S:16 F:2 SMO(1,3)



387.8580 S:16 F:2 SMO(1,3)

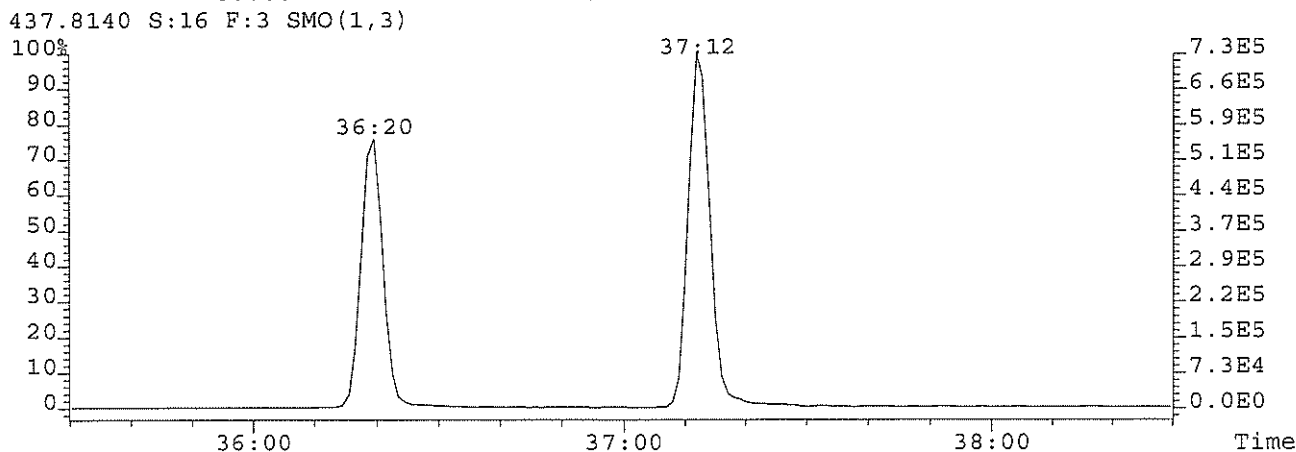
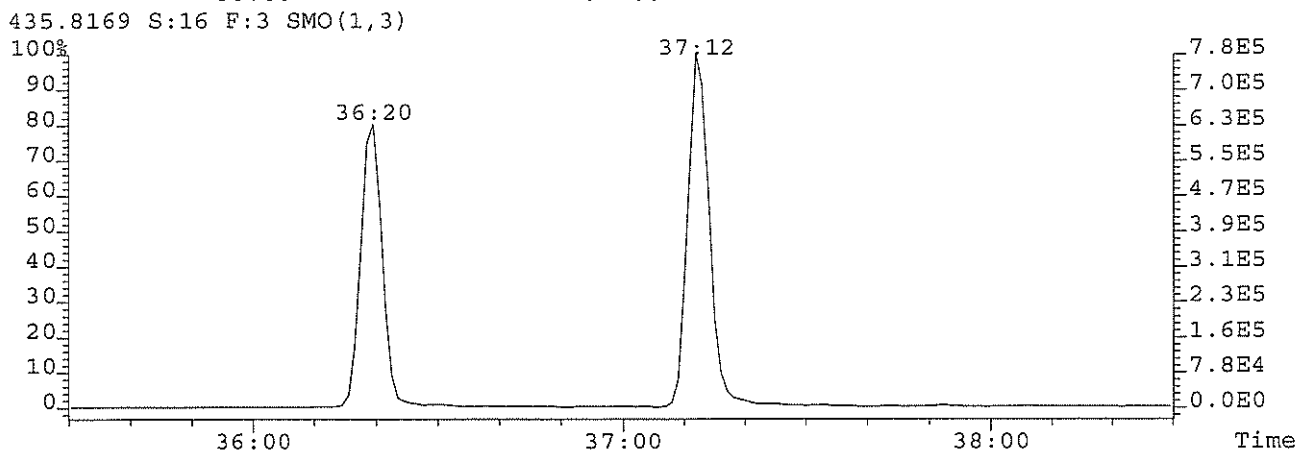
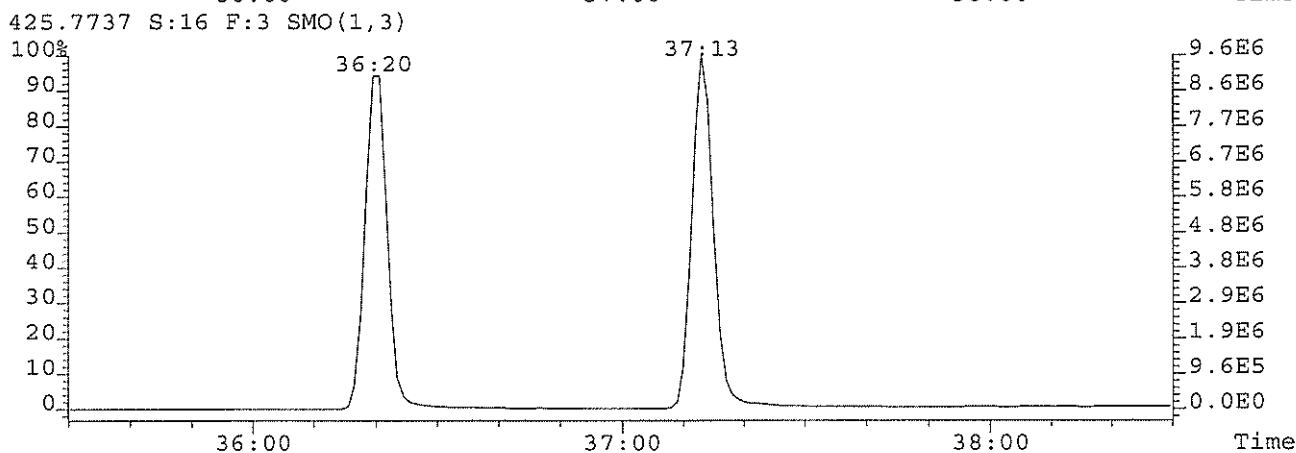
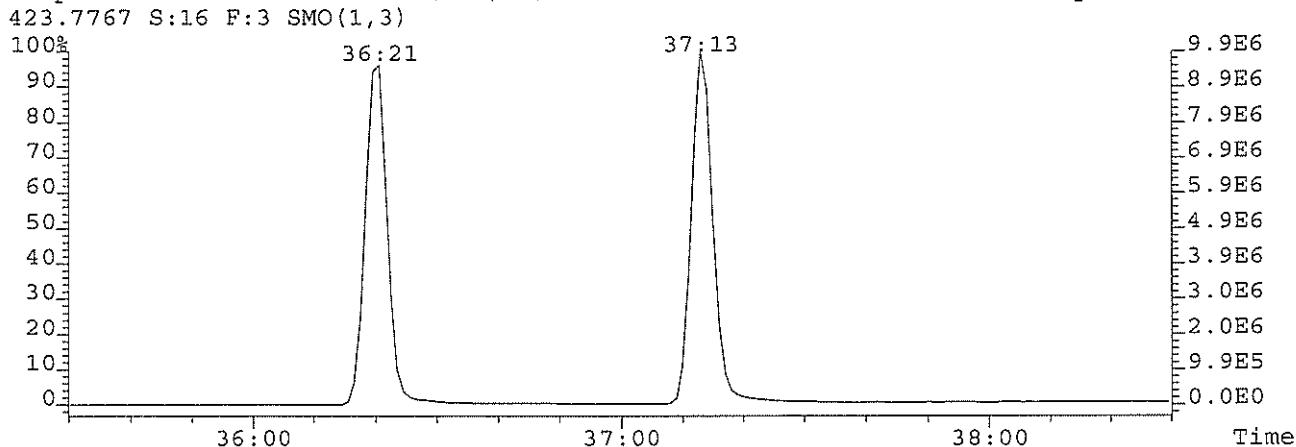


File:130713 #1-562 Acq:14-JUL-2013 00:37:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0962 3 Exp:RH-PD22



PCDFsクロマトグラム (9)  
(HpCDFs)

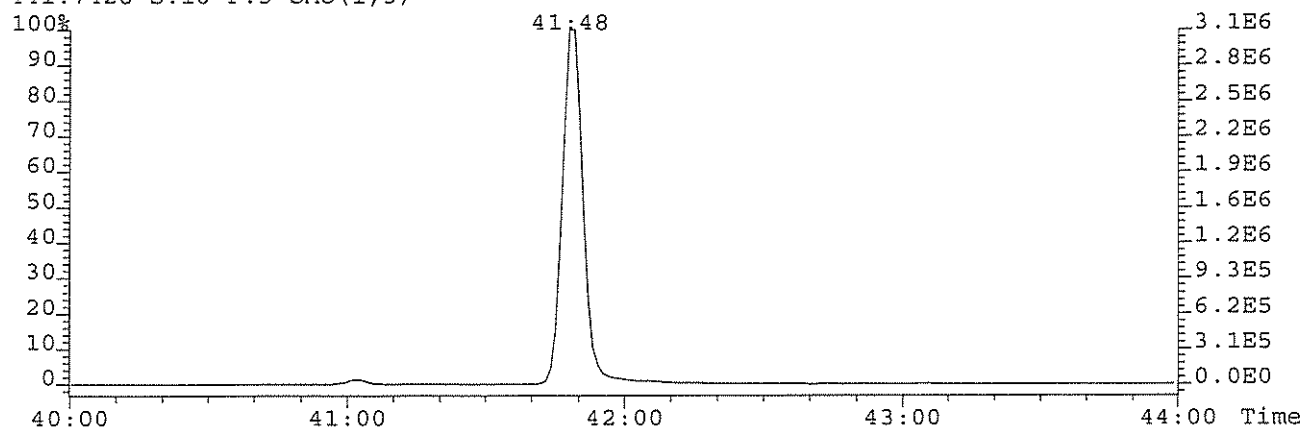
File:130713 #1-562 Acq:14-JUL-2013 00:37:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0962 3 Exp:RH-PD22



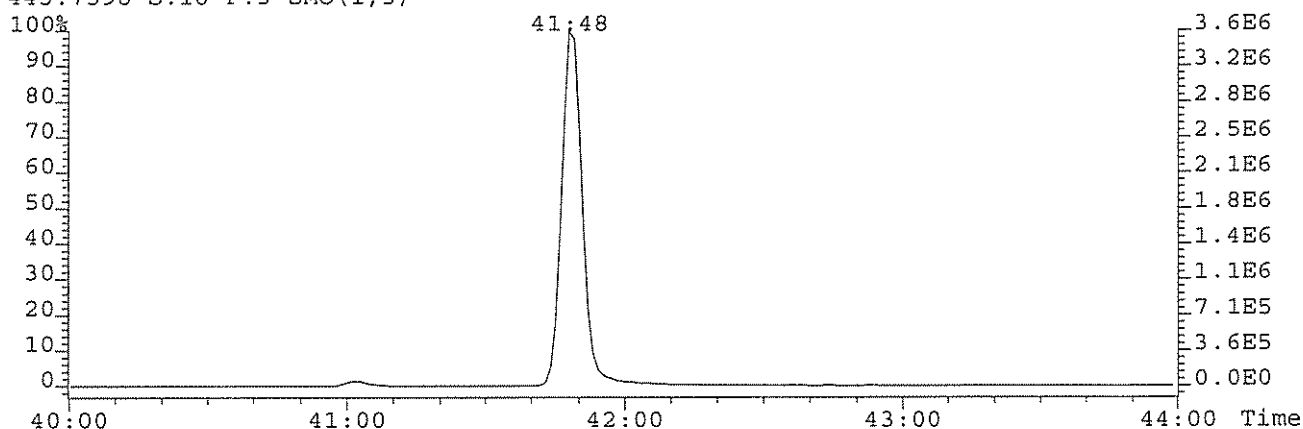
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130713 #1-562 Acq:14-JUL-2013 00:37:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0962 3 Exp:RH-PD22

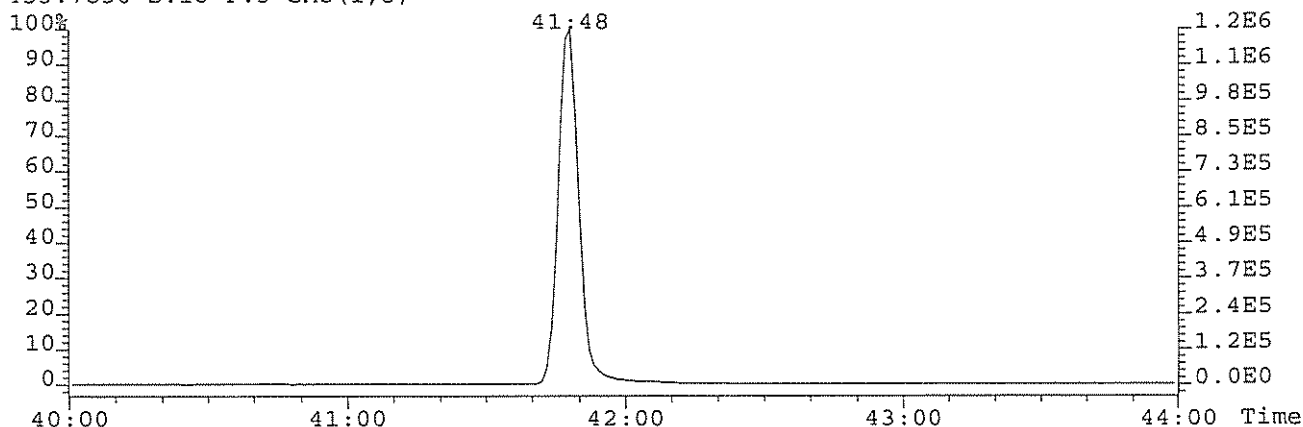
441.7428 S:16 F:3 SMO(1,3)



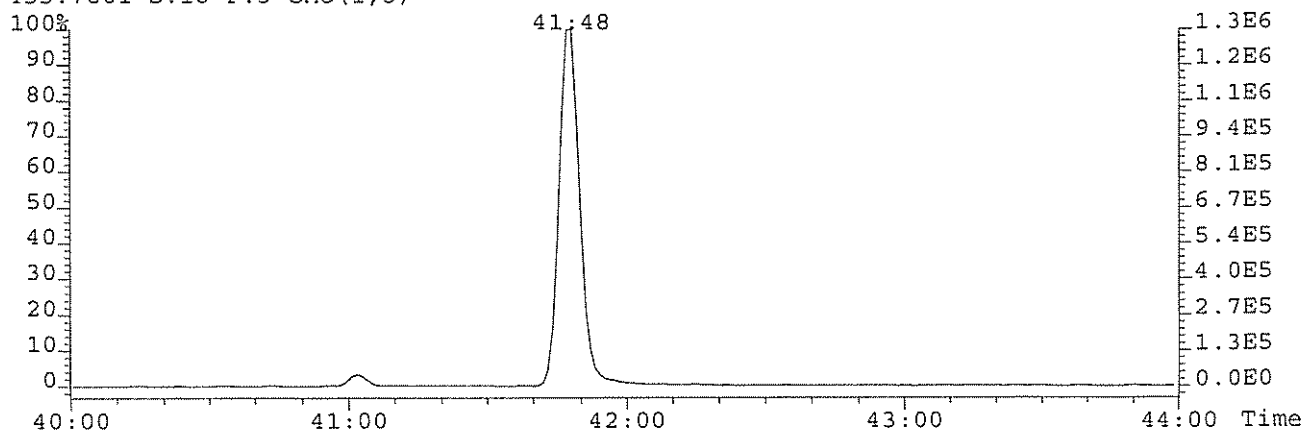
443.7398 S:16 F:3 SMO(1,3)



453.7830 S:16 F:3 SMO(1,3)

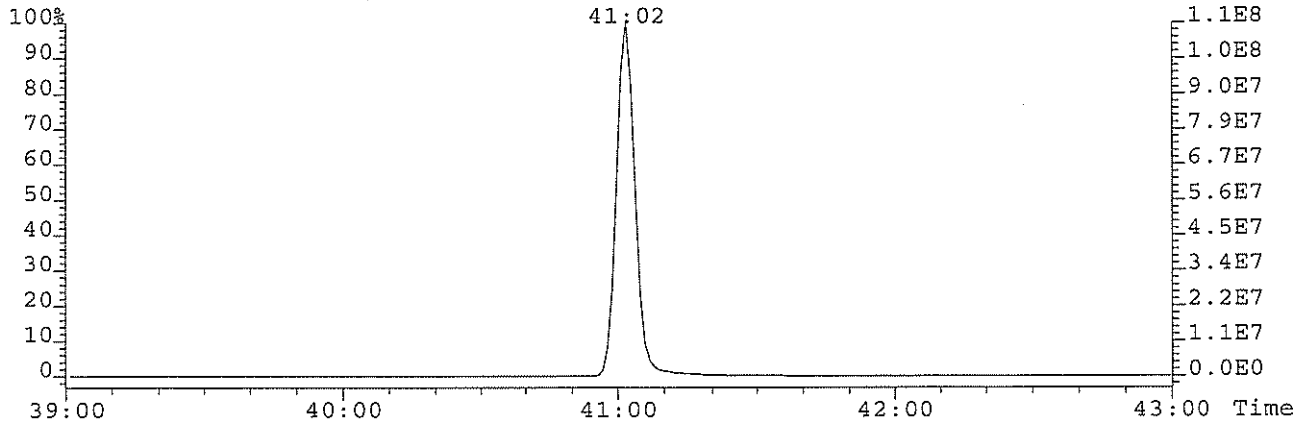


455.7801 S:16 F:3 SMO(1,3)

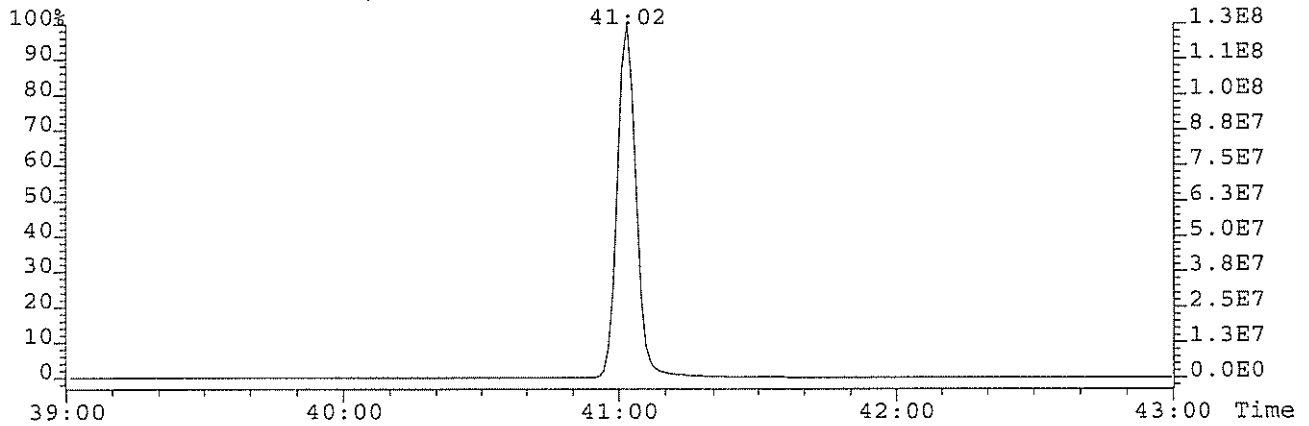


PCDFsクロマトグラム (11)  
(OCDF)

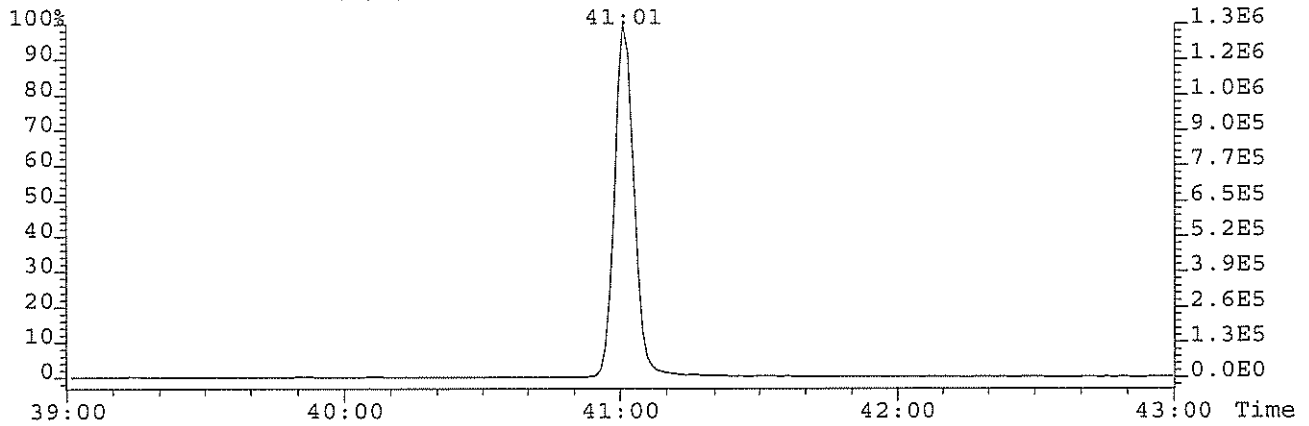
File:130713 #1-562 Acq:14-JUL-2013 00:37:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0962 3 Exp:RH-PD22  
457.7377 S:16 F:3 SMO(1,3)



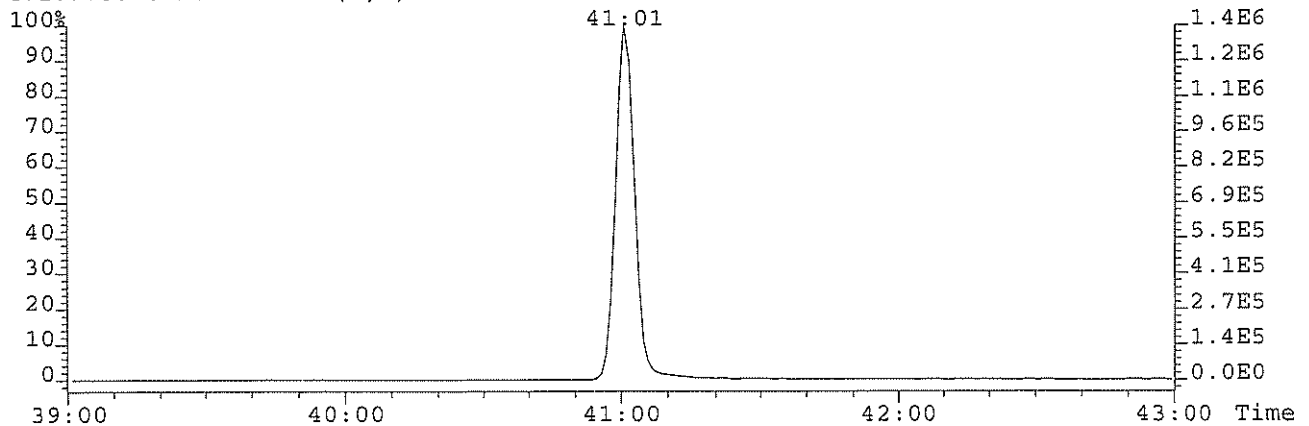
459.7348 S:16 F:3 SMO(1,3)



469.7780 S:16 F:3 SMO(1,3)



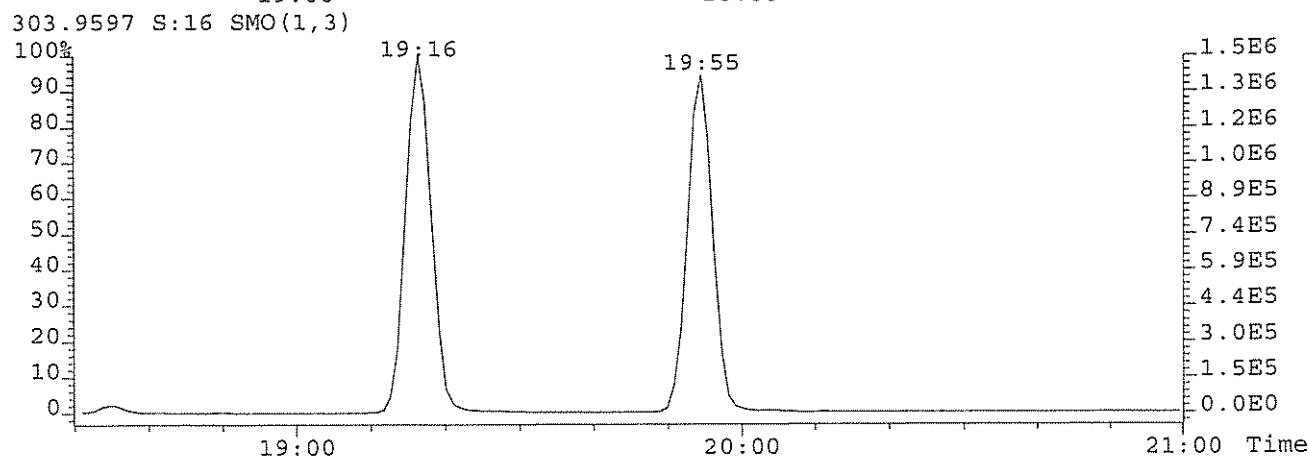
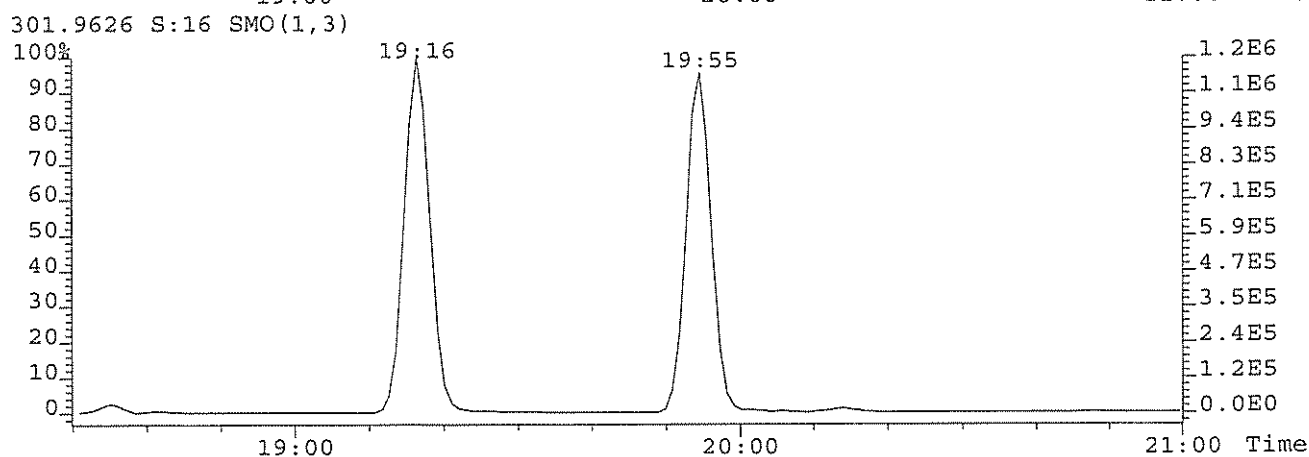
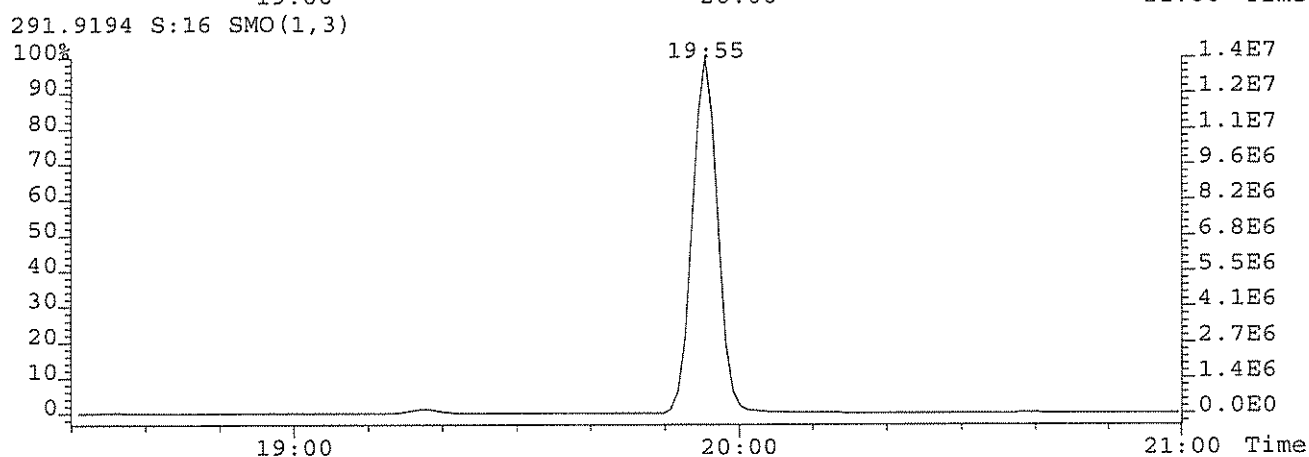
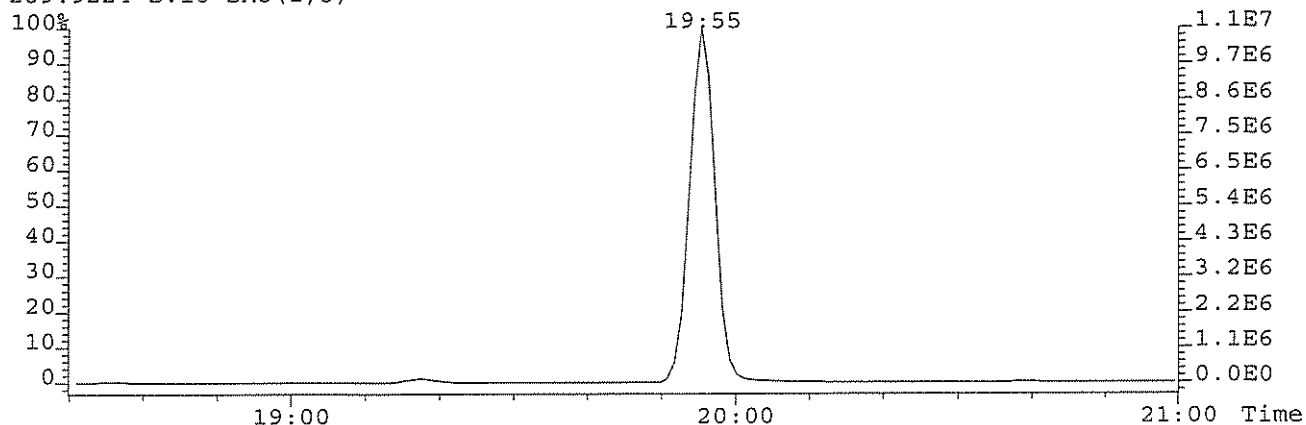
471.7750 S:16 F:3 SMO(1,3)



PCDDsクロマトグラム (12)  
(OCDD)

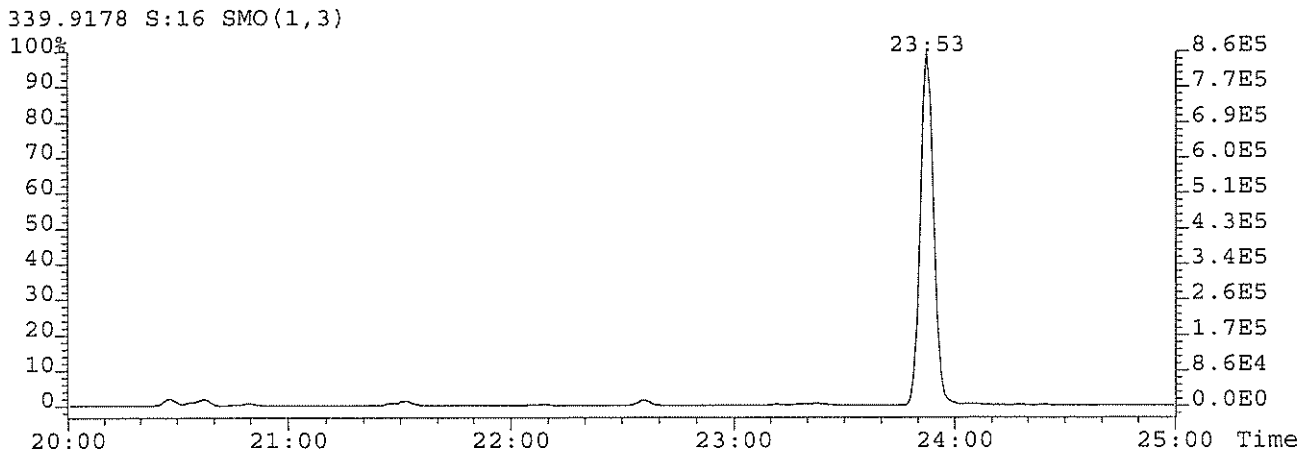
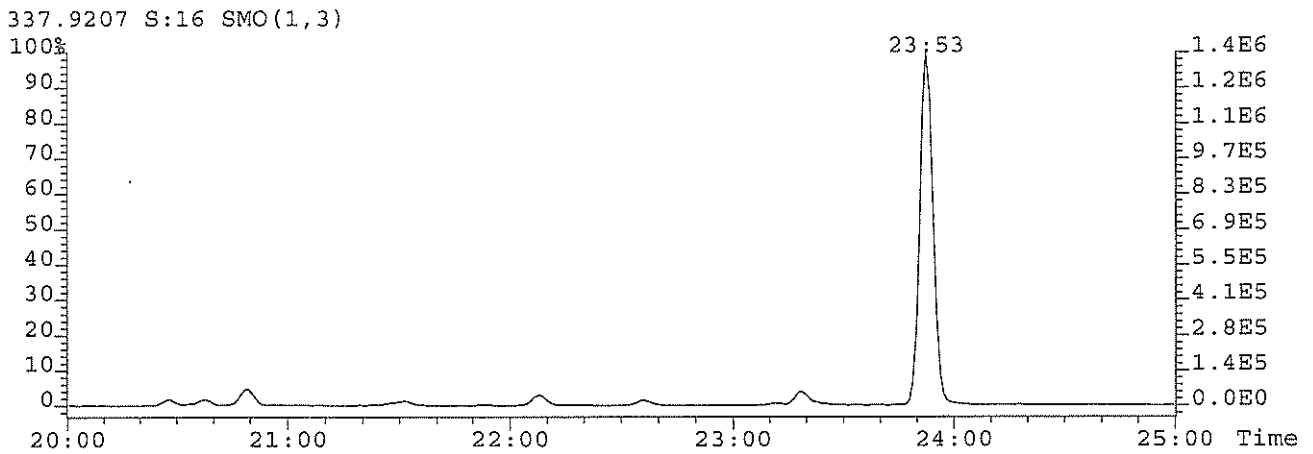
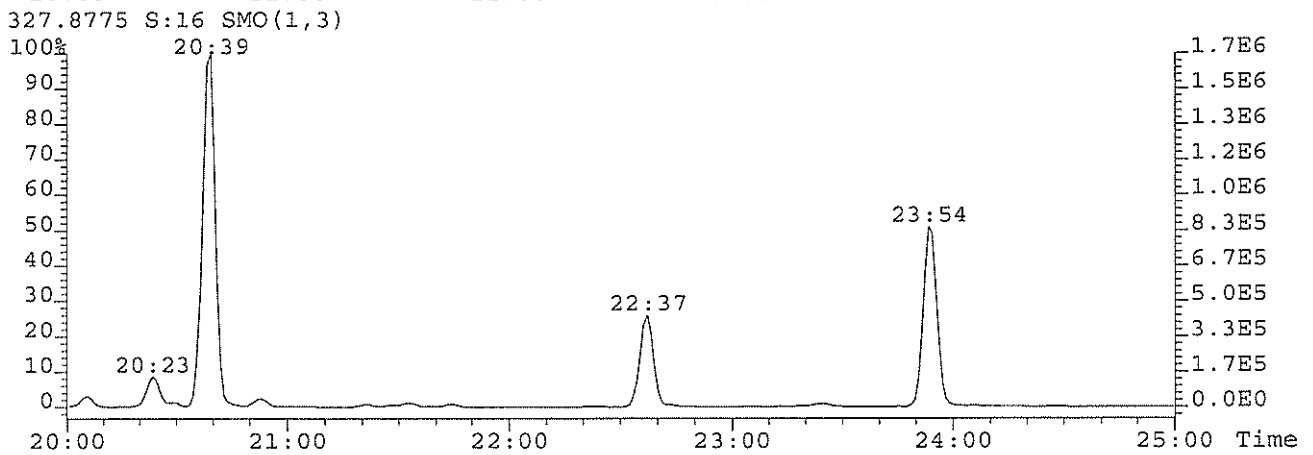
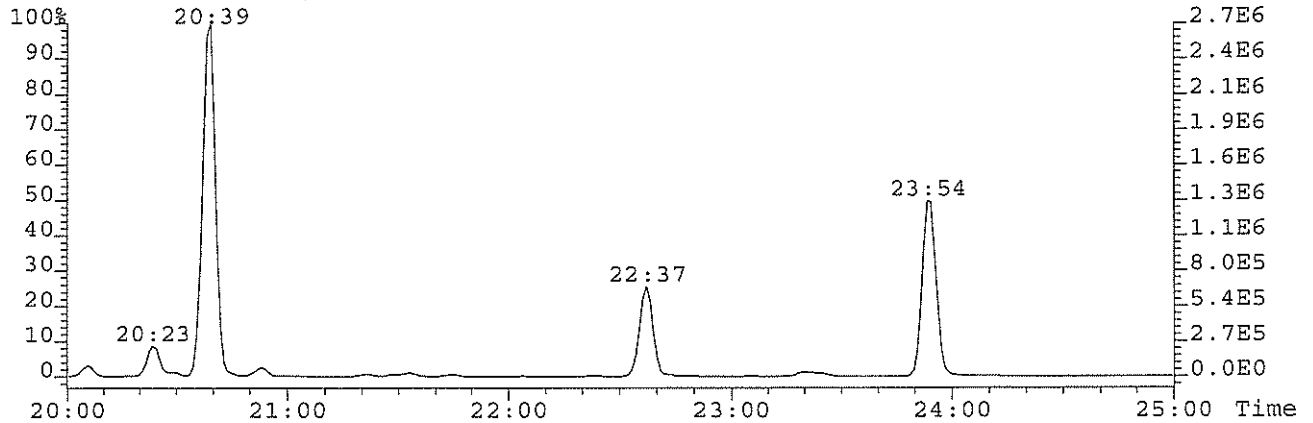


File:130713 #1-1430 Acq:14-JUL-2013 00:37:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0962 3 Exp:RH-PD22  
289.9224 S:16 SMO(1,3)



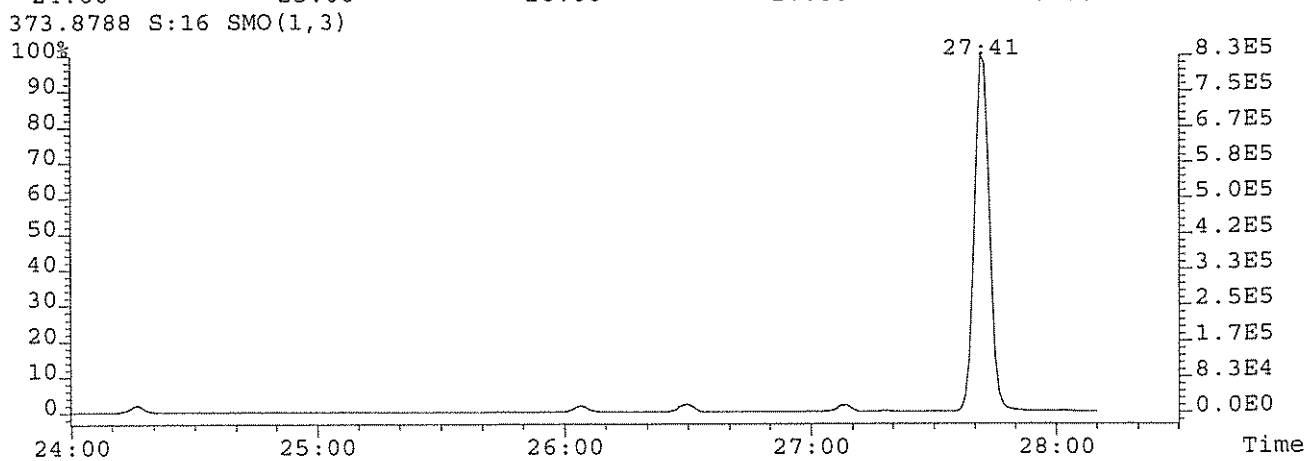
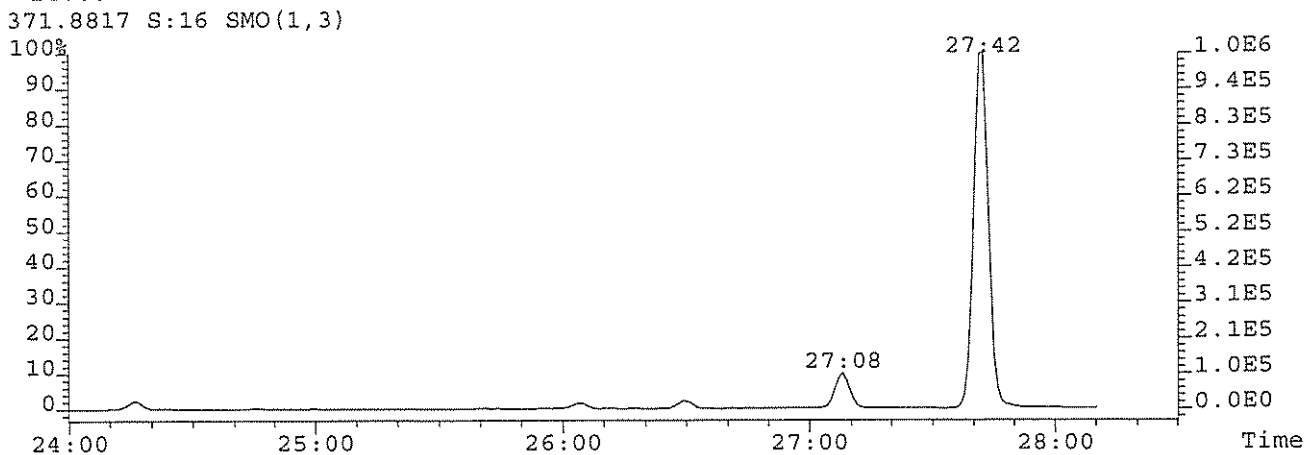
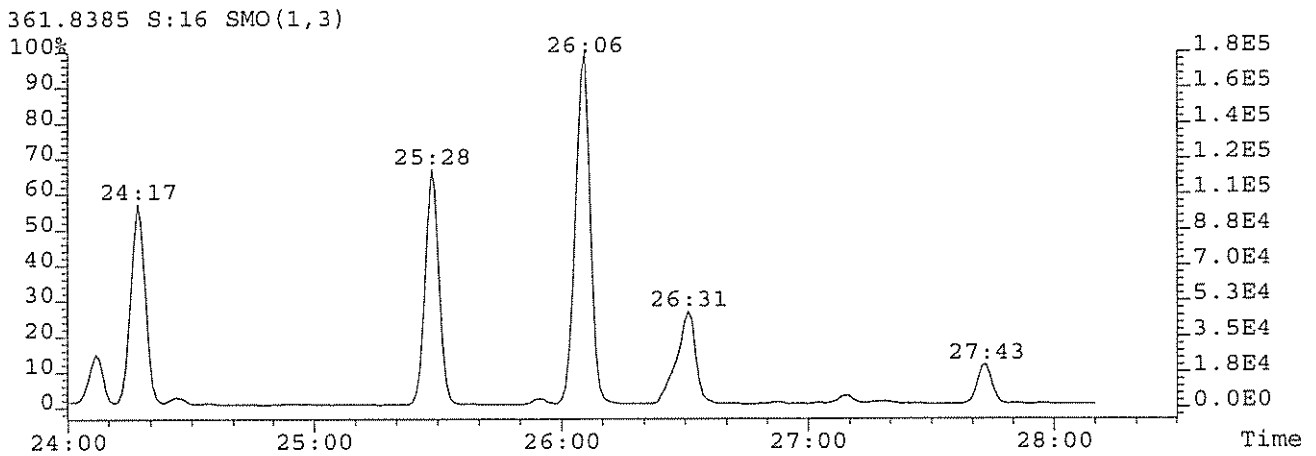
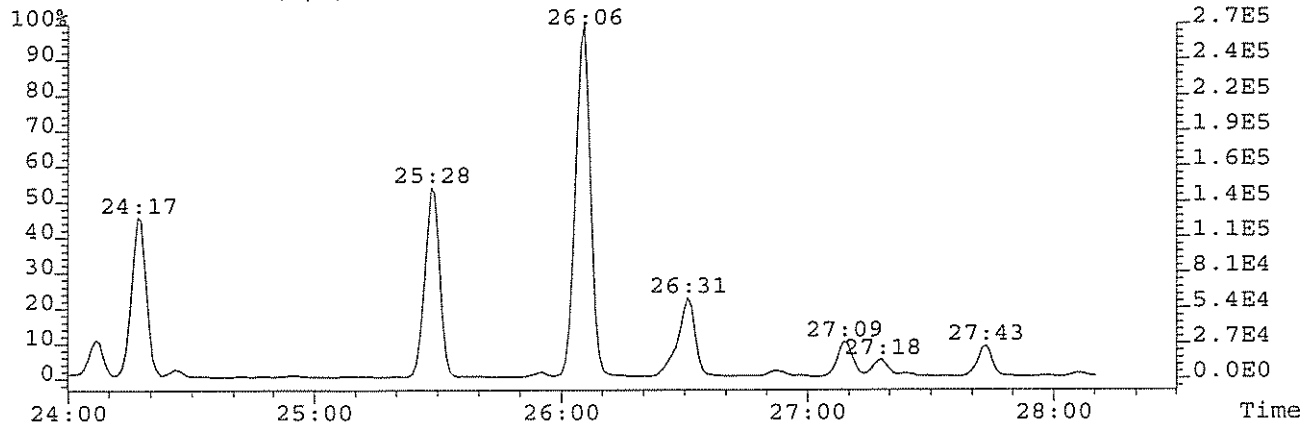
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130713 #1-1430 Acq:14-JUL-2013 00:37:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0962 3 Exp:RH-PD22  
325.8804 S:16 SMO(1,3)



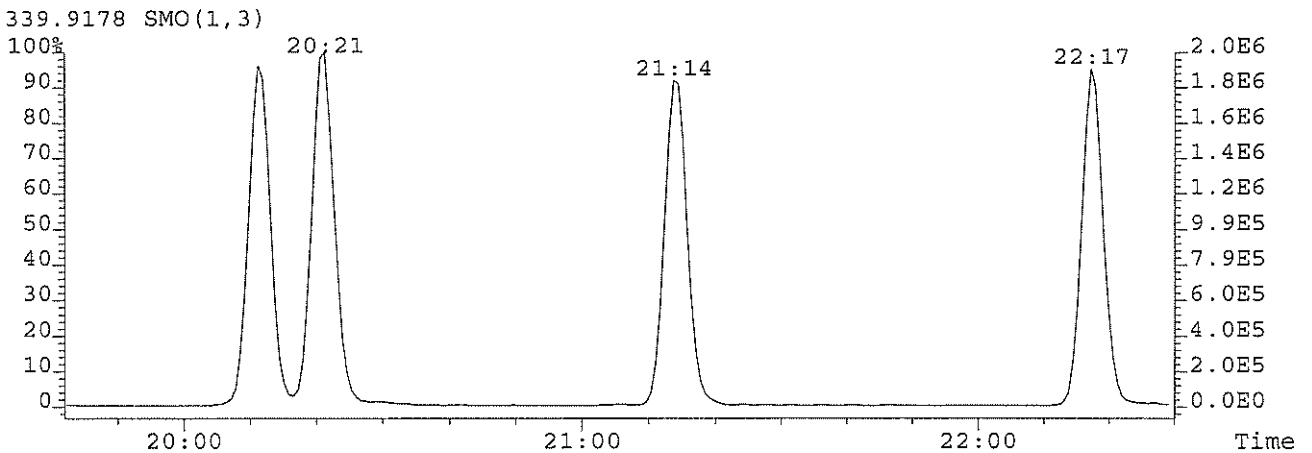
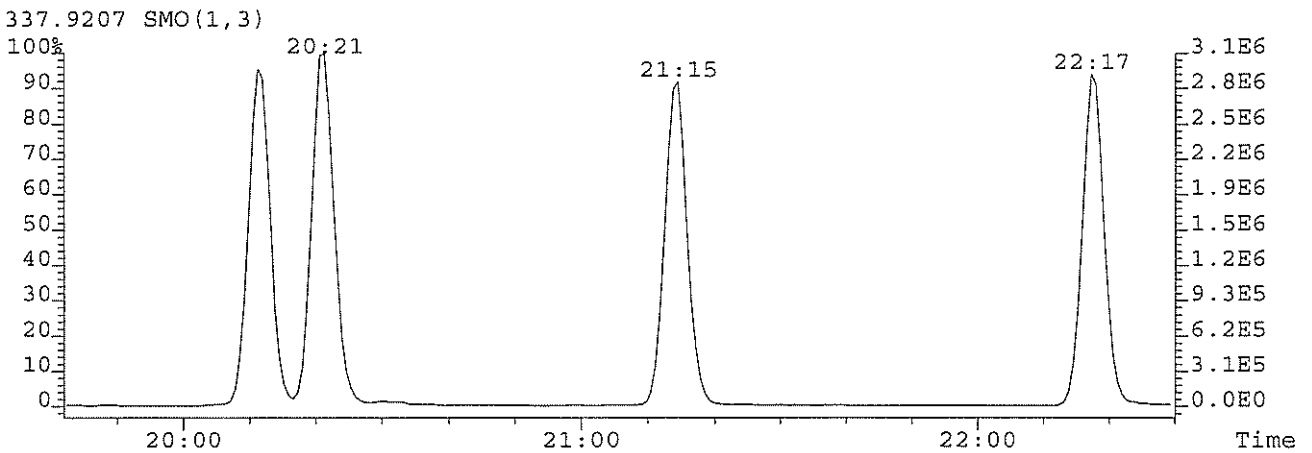
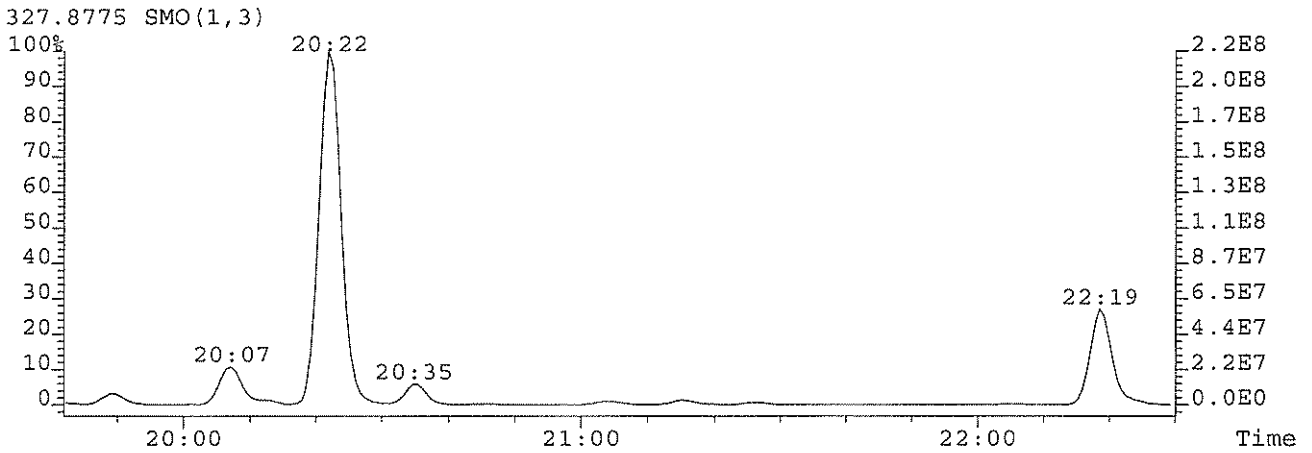
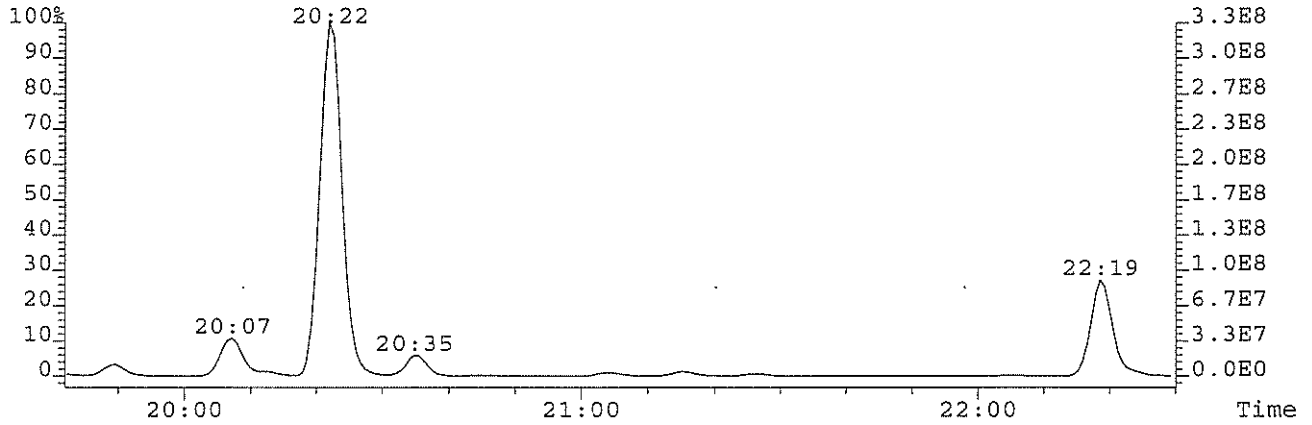
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130713 #1-1430 Acq:14-JUL-2013 00:37:42 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#16 File Text:RH-12ms(5-8,nP) Text:XE13 0962 3 Exp:RH-PD22  
359.8415 S:16 SMO(1,3)



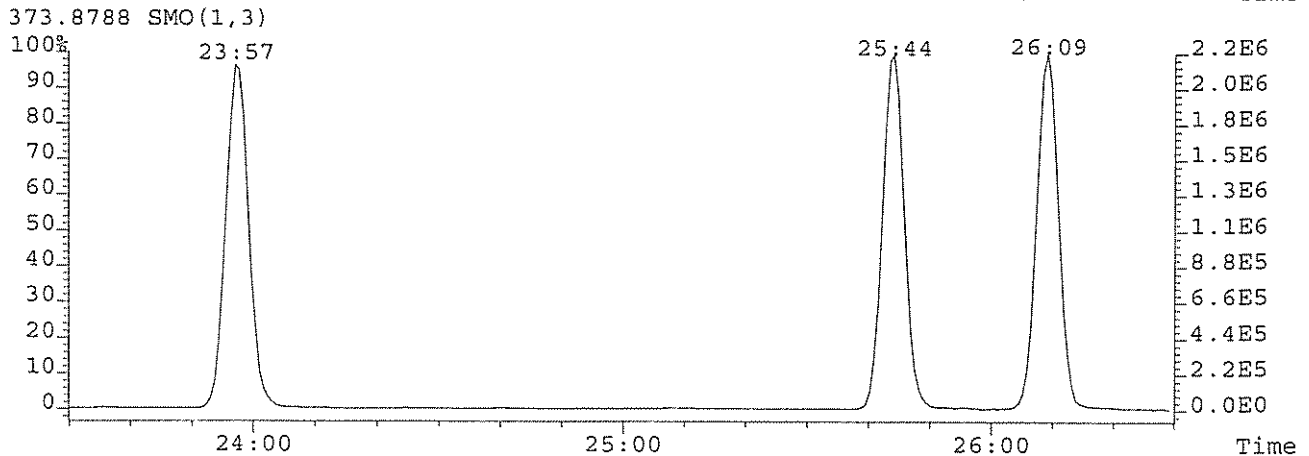
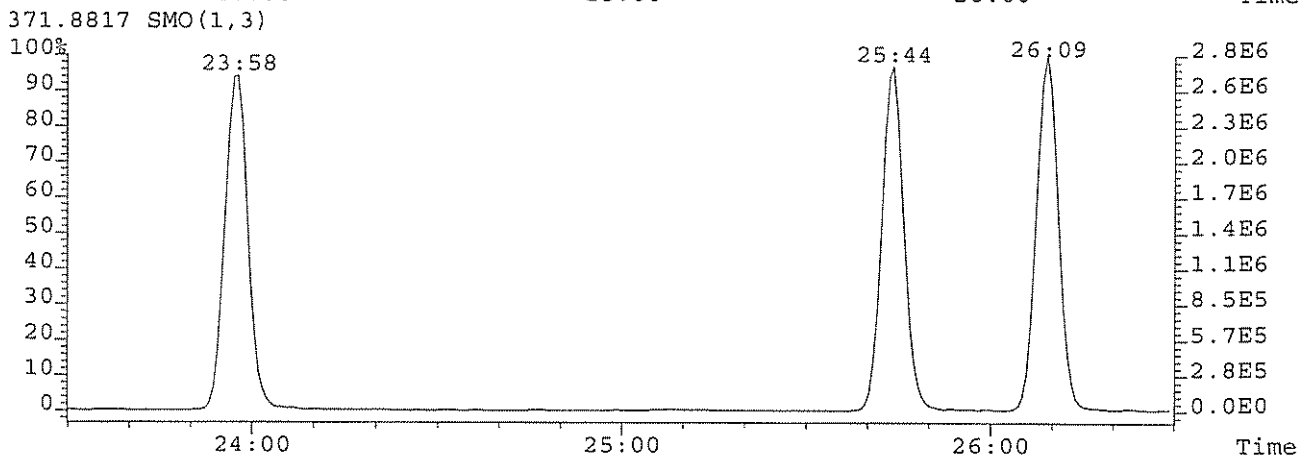
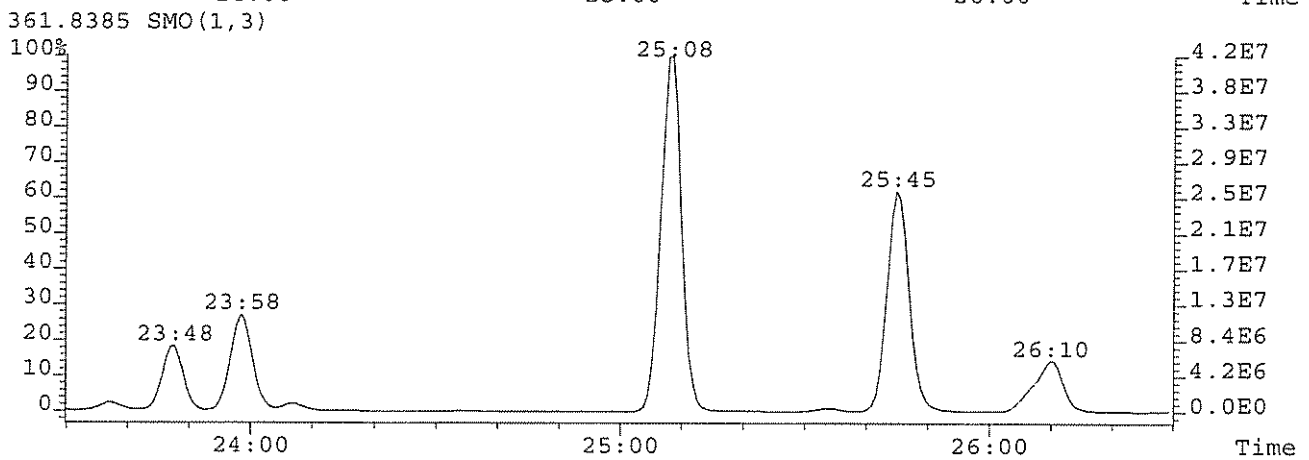
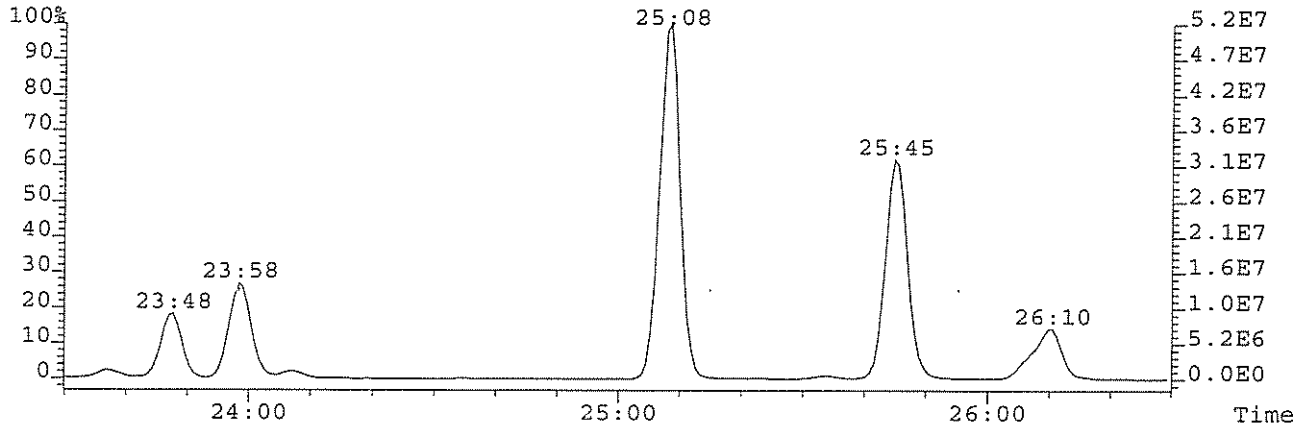
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130716-2 #1-2899 Acq:16-JUL-2013 14:33:46 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(mP) Text:XE13 0962 2 Exp:RH-MP11  
325.8804 SMO(1,3)



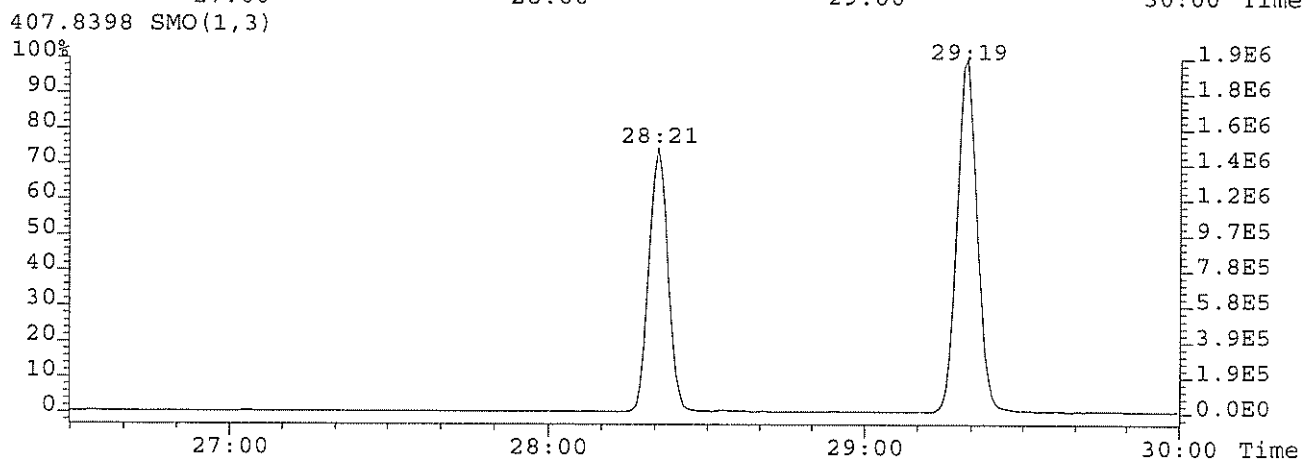
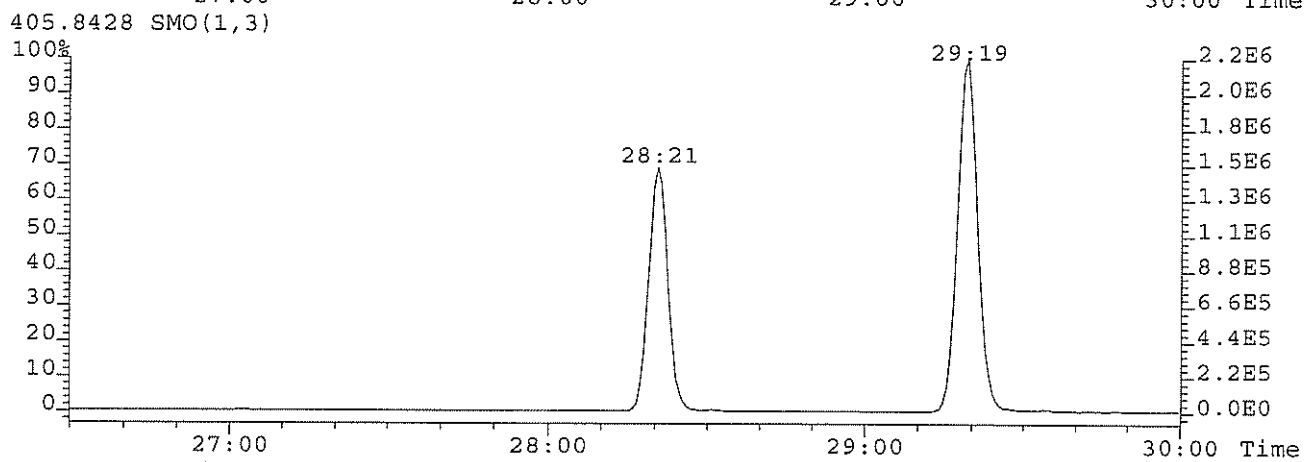
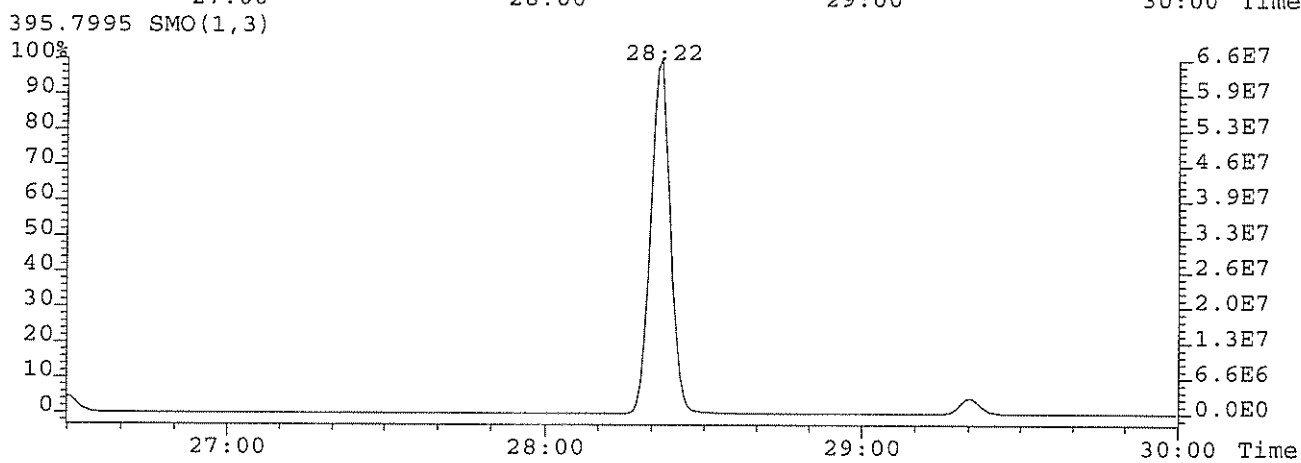
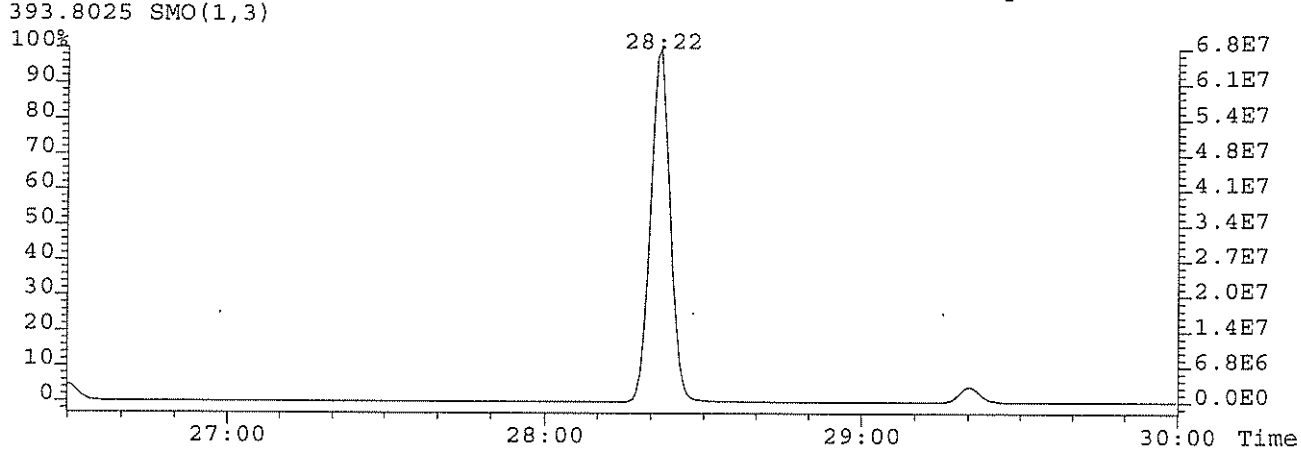
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130716-2 #1-2899 Acq:16-JUL-2013 14:33:46 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(mP) Text:XE13 0962 2 Exp:RH-MP11  
359.8415 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130716-2 #1-2899 Acq:16--JUL-2013 14:33:46 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(mP) Text:XE13 0962 2 Exp:RH-MP11

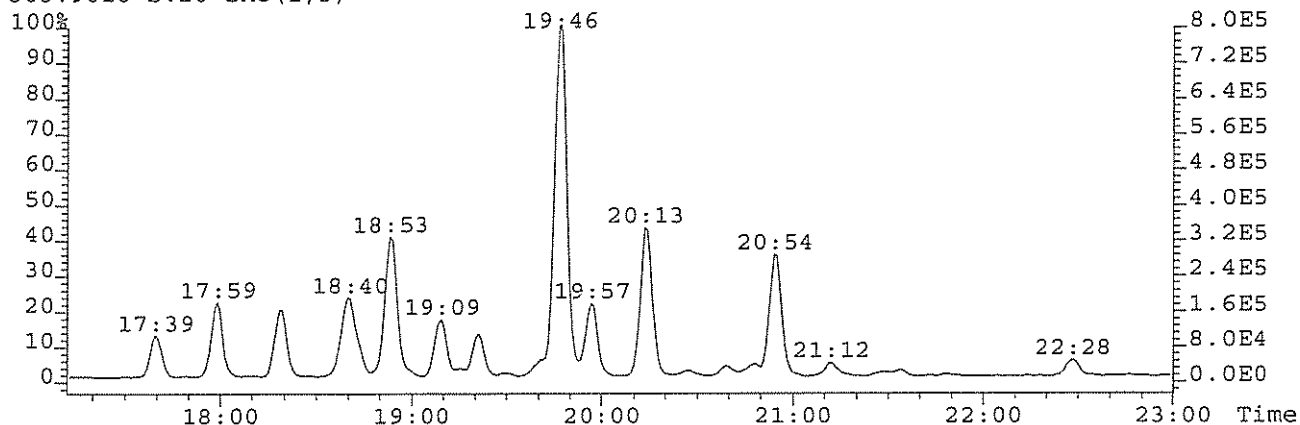


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

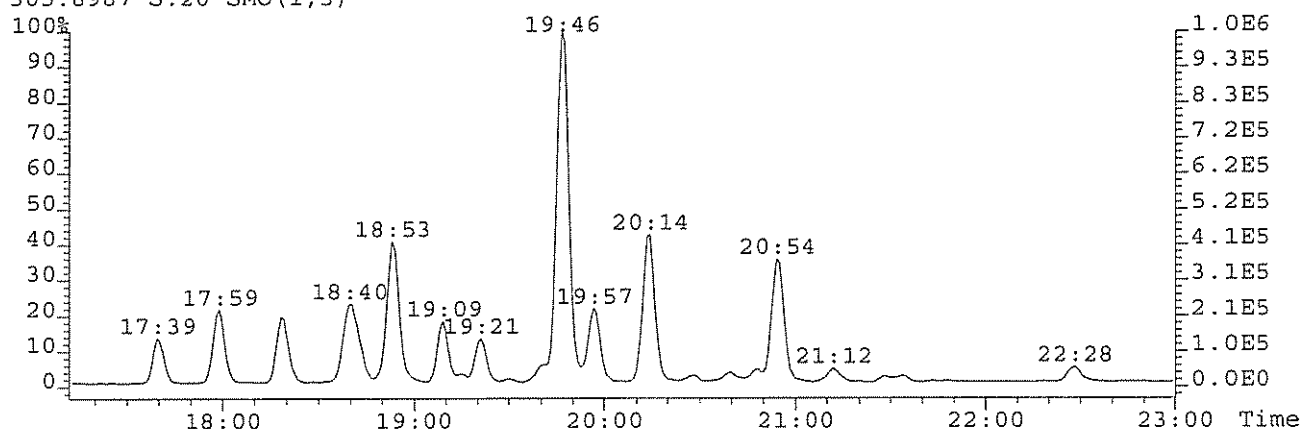
試料管理番号	XE 130963
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.17

File:130712-2 #1-1578 Acq:13-JUL-2013 07:18:15 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:BPX-DXN(4-6DXN) Text:XE13 0963 Exp:BPX04

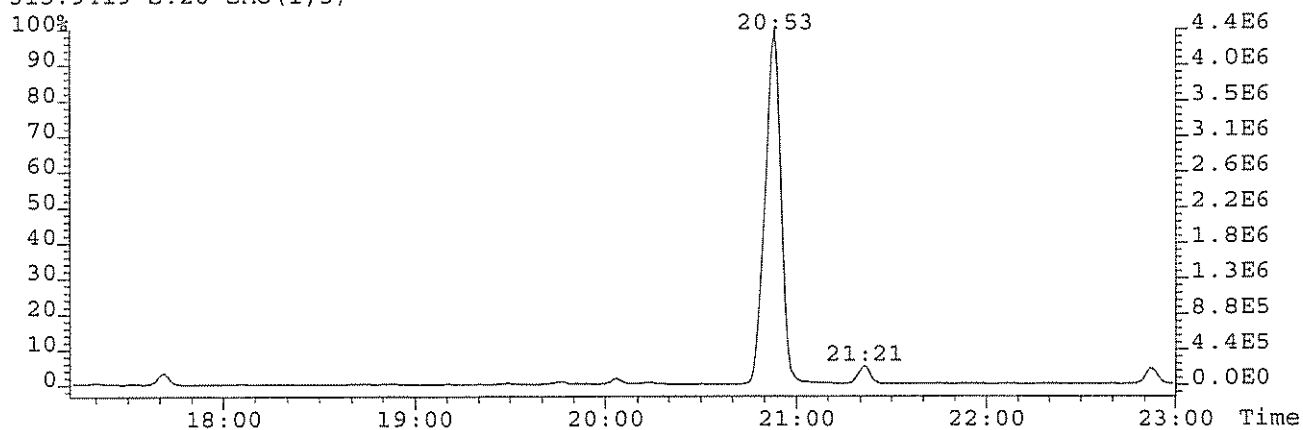
303.9016 S:20 SMO(1,3)



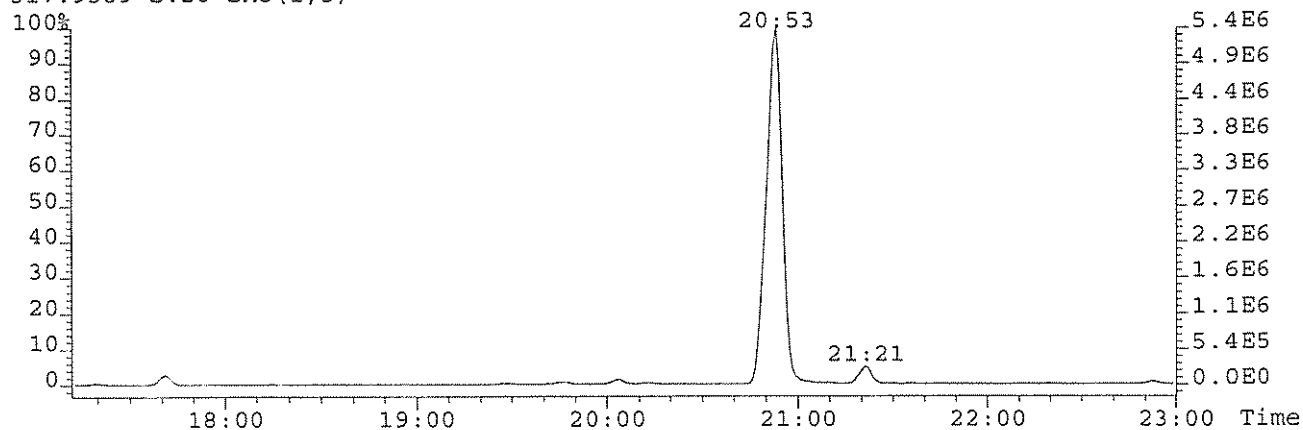
305.8987 S:20 SMO(1,3)



315.9419 S:20 SMO(1,3)



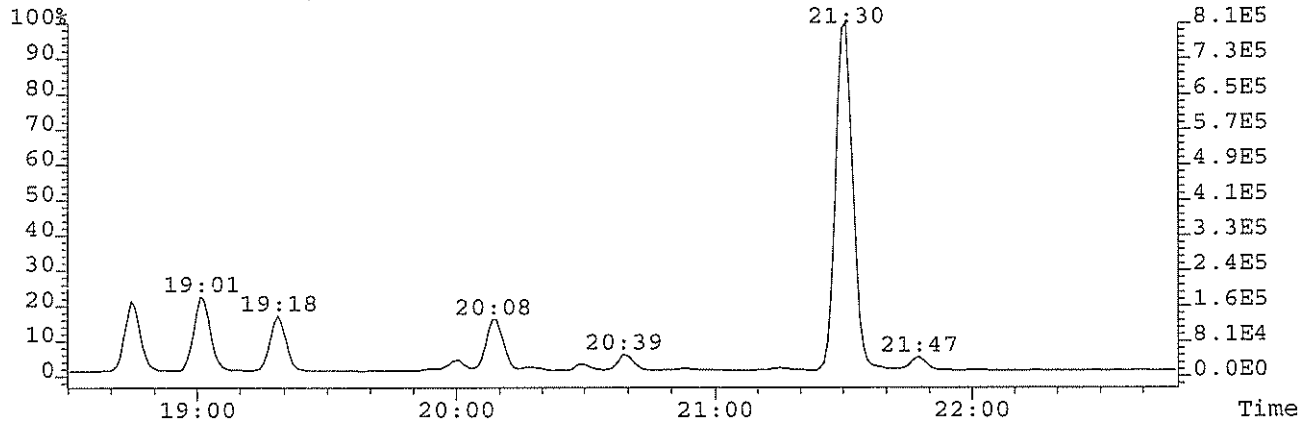
317.9389 S:20 SMO(1,3)



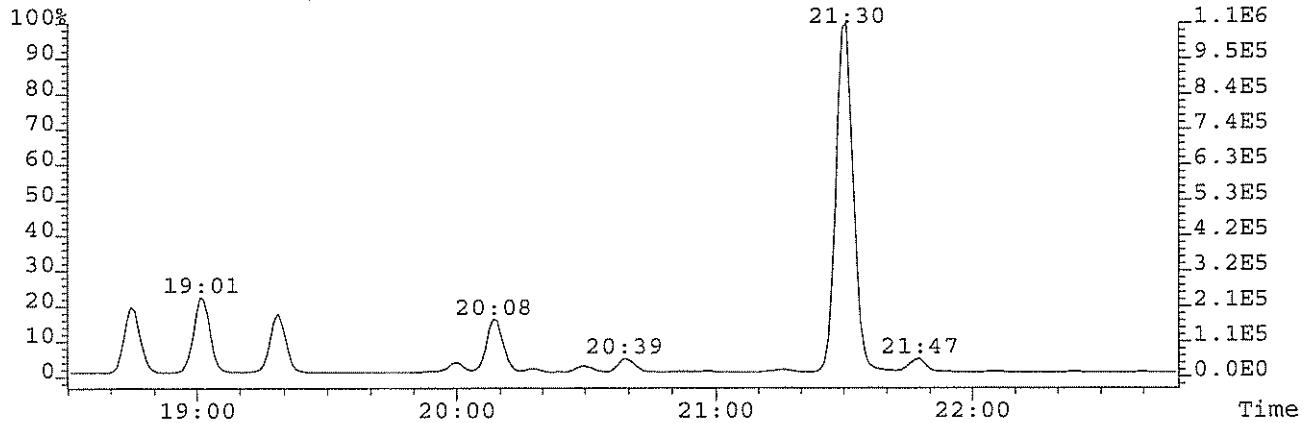
PCDFsクロマトグラム (1)  
(TeCDFs)



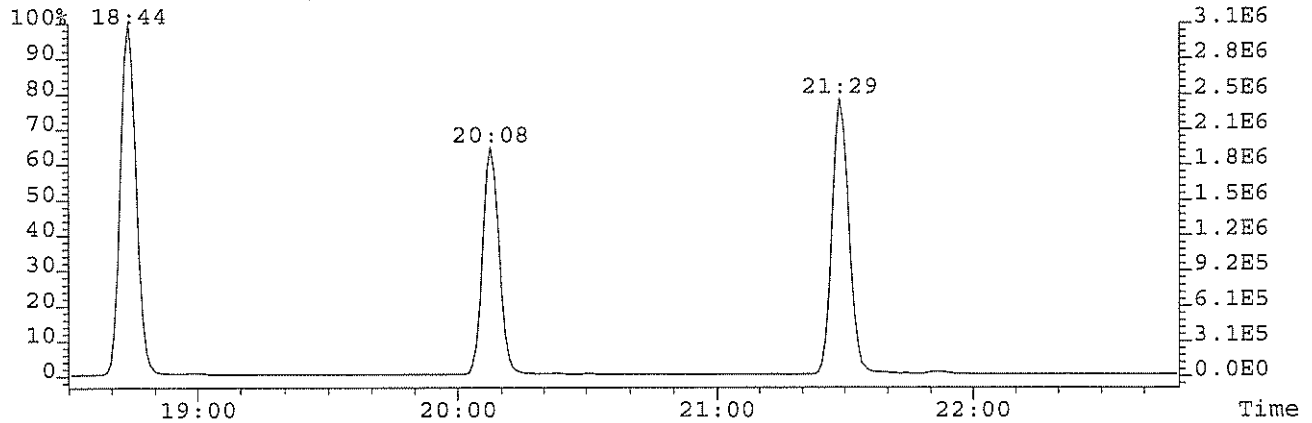
File:130712-2 #1-1578 Acq:13-JUL-2013 07:18:15 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:BPX-DXN(4-6DXN) Text:XE13 0963 Exp:BPX04  
319.8965 S:20 SMO(1,3)



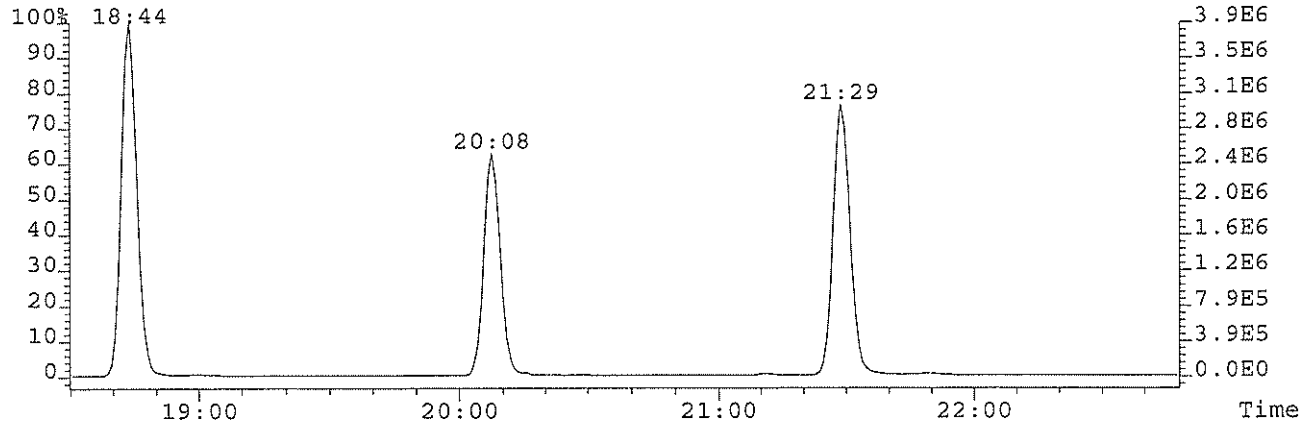
321.8936 S:20 SMO(1,3)



331.9368 S:20 SMO(1,3)



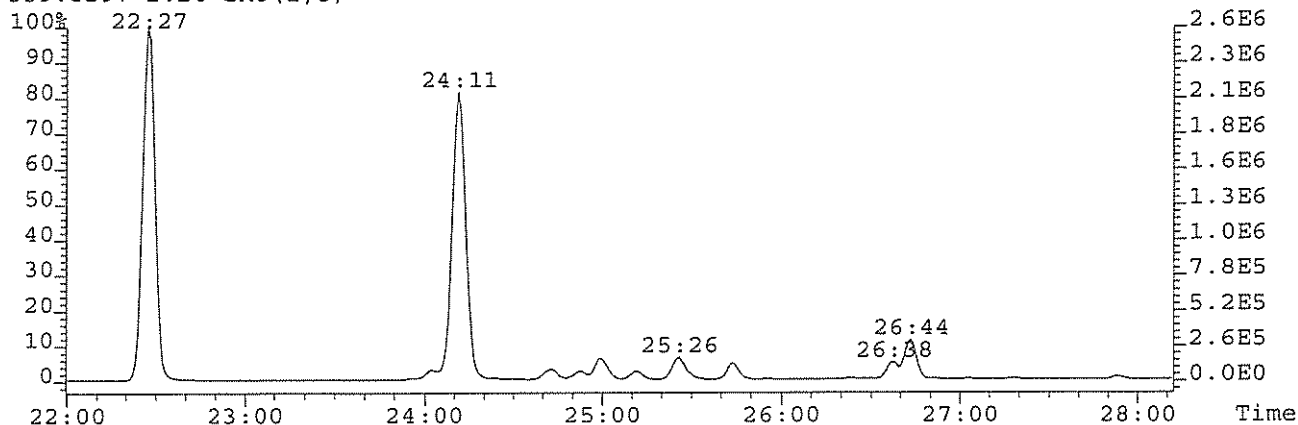
333.9339 S:20 SMO(1,3)



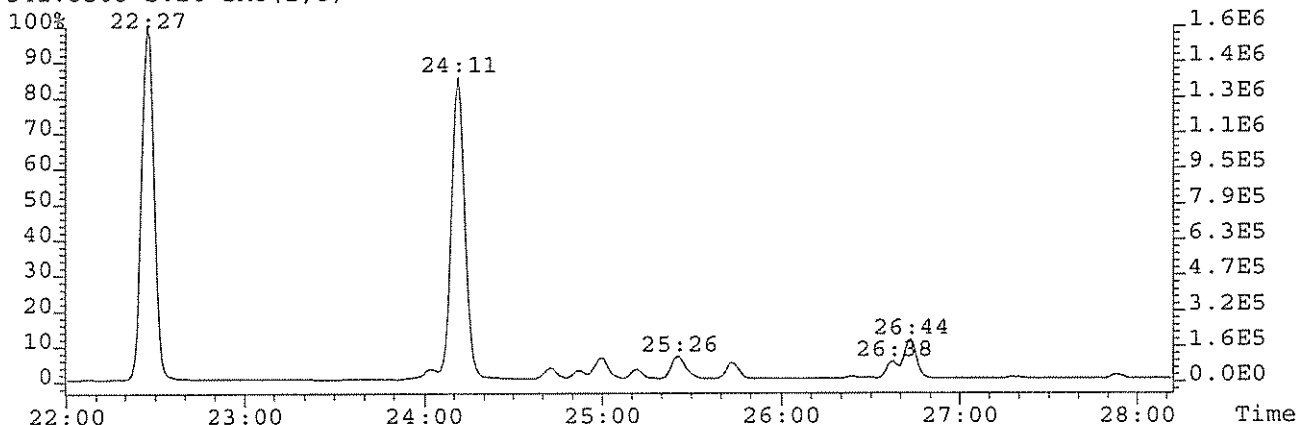
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130712-2 #1-1578 Acq:13-JUL-2013 07:18:15 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:BPX-DXN(4-6DXN) Text:XE13 0963 Exp:BPX04

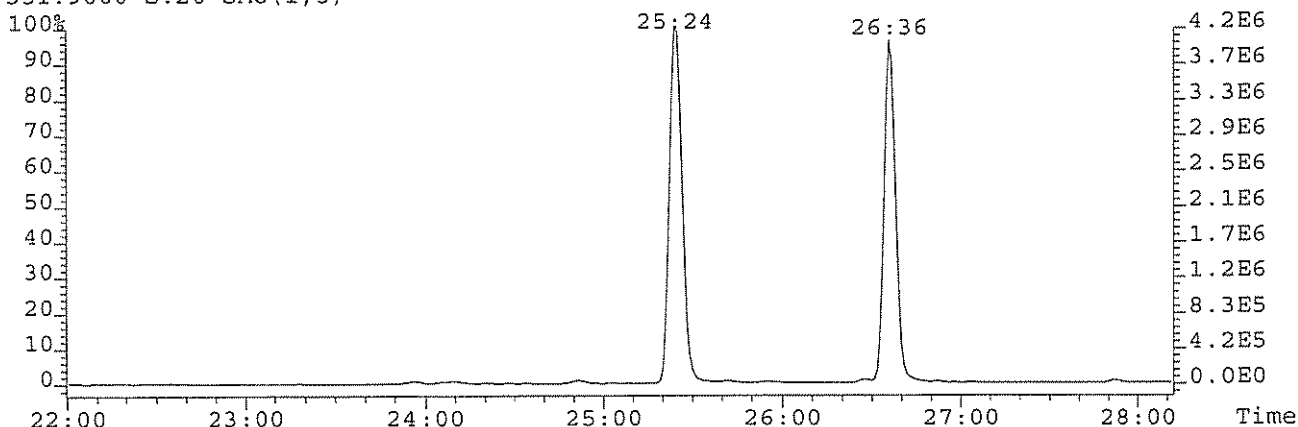
339.8597 S:20 SMO(1,3)



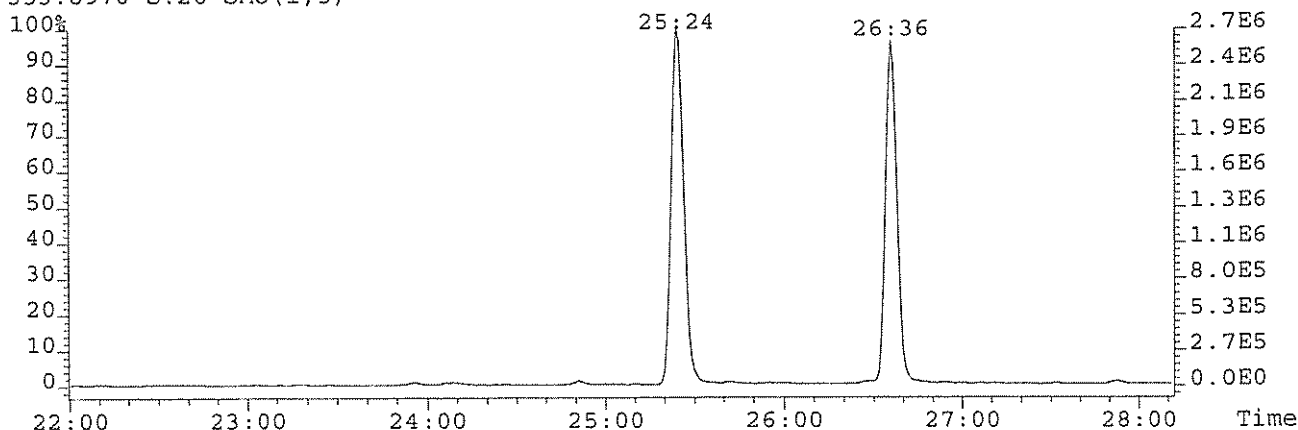
341.8568 S:20 SMO(1,3)



351.9000 S:20 SMO(1,3)



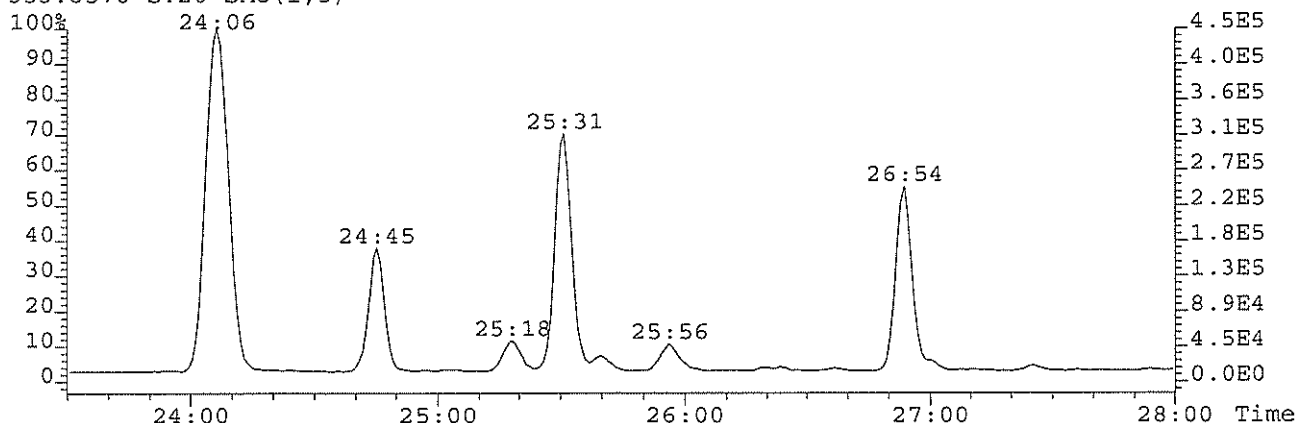
353.8970 S:20 SMO(1,3)



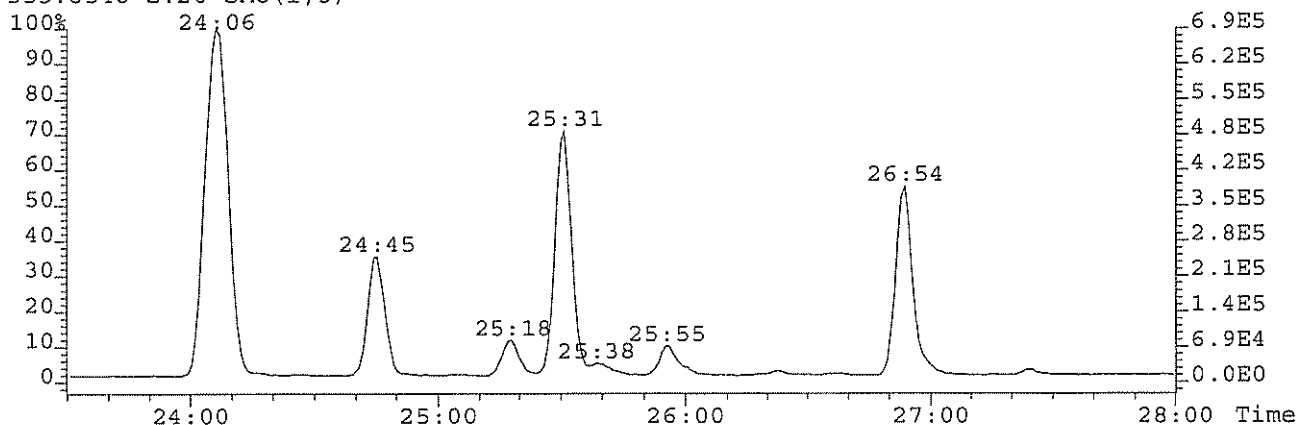
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 07:18:15 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:BPX-DXN(4-6DXN) Text:XE13 0963 Exp:BPX04

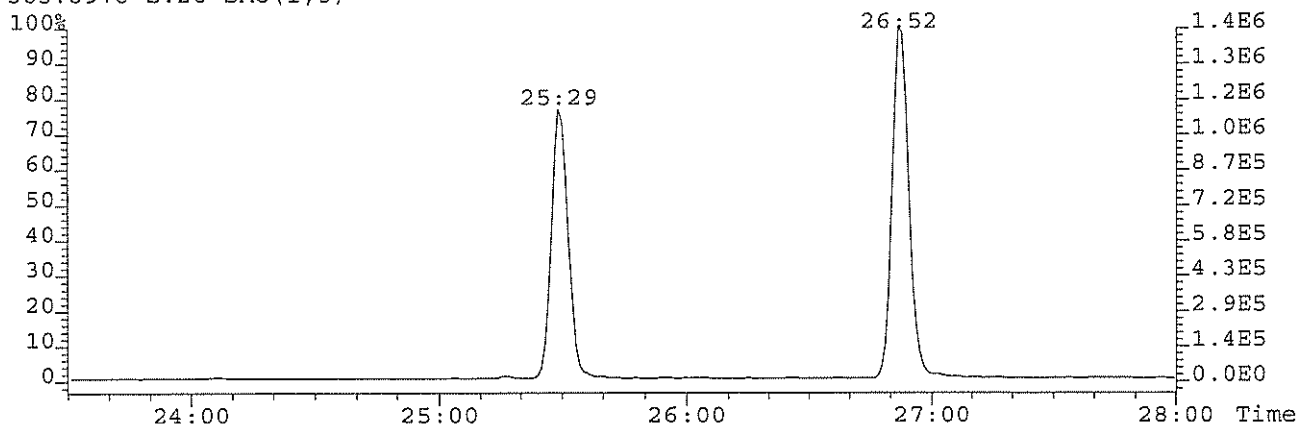
353.8576 S:20 SMO(1,3)



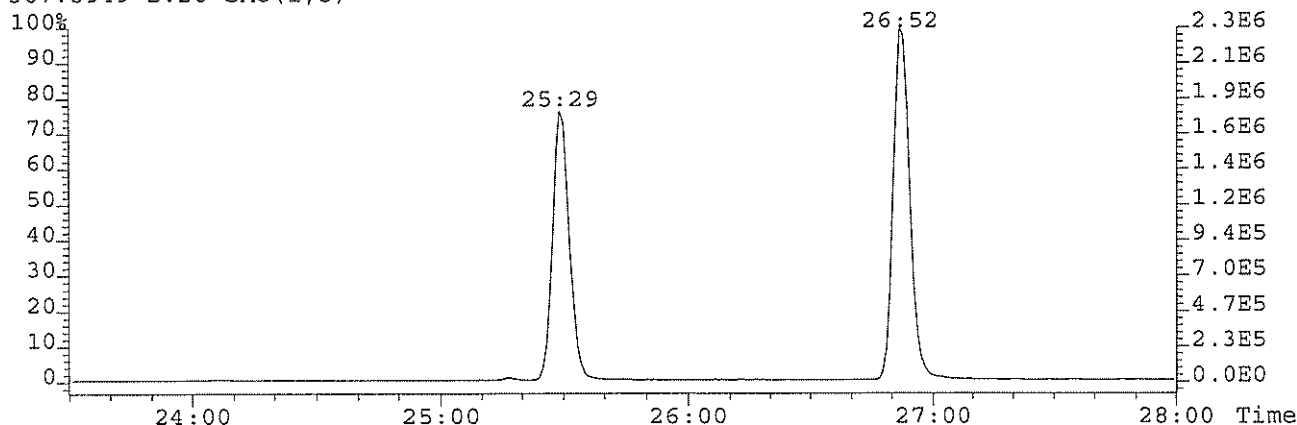
355.8546 S:20 SMO(1,3)



365.8978 S:20 SMO(1,3)

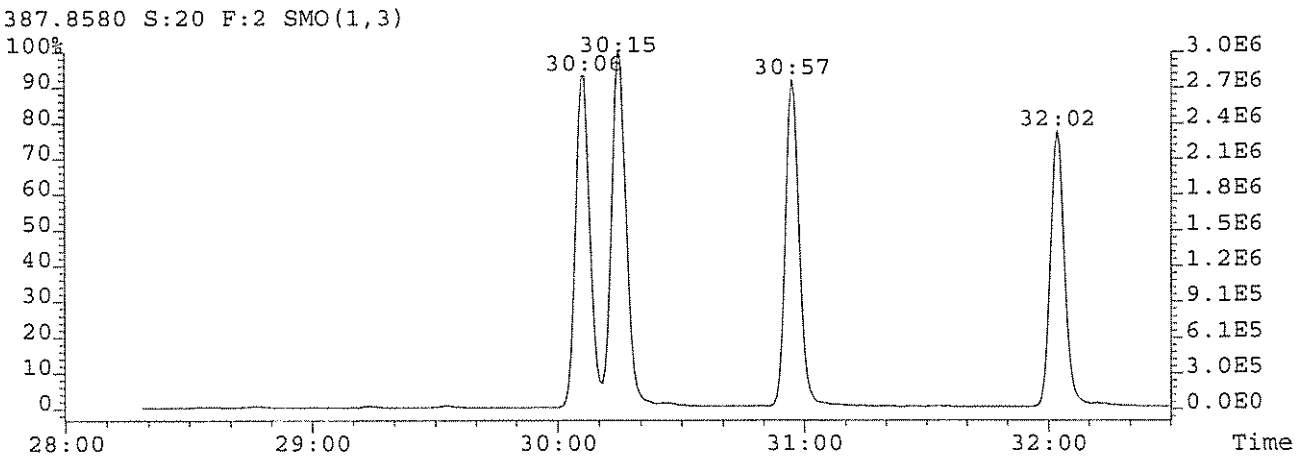
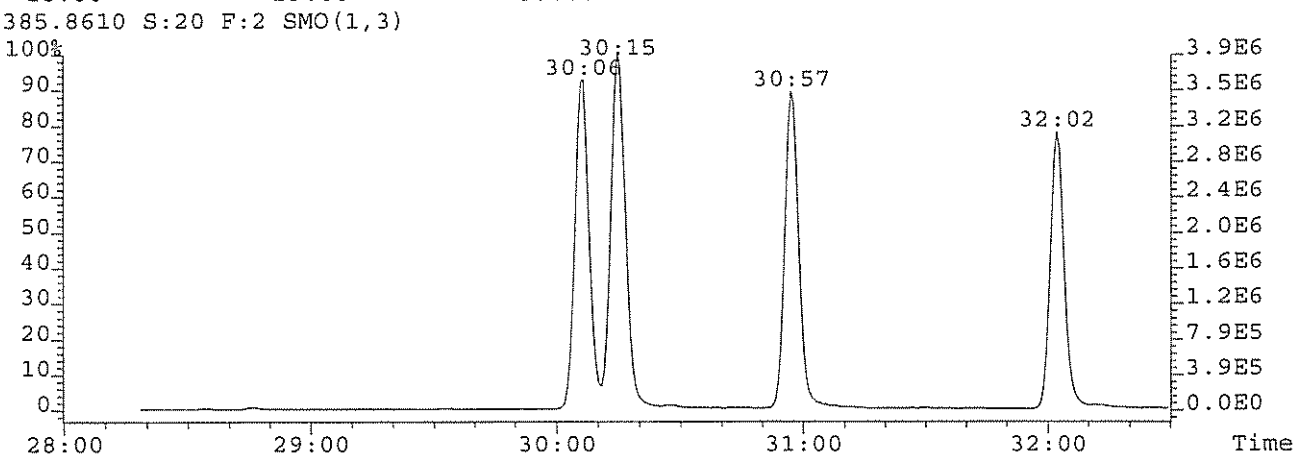
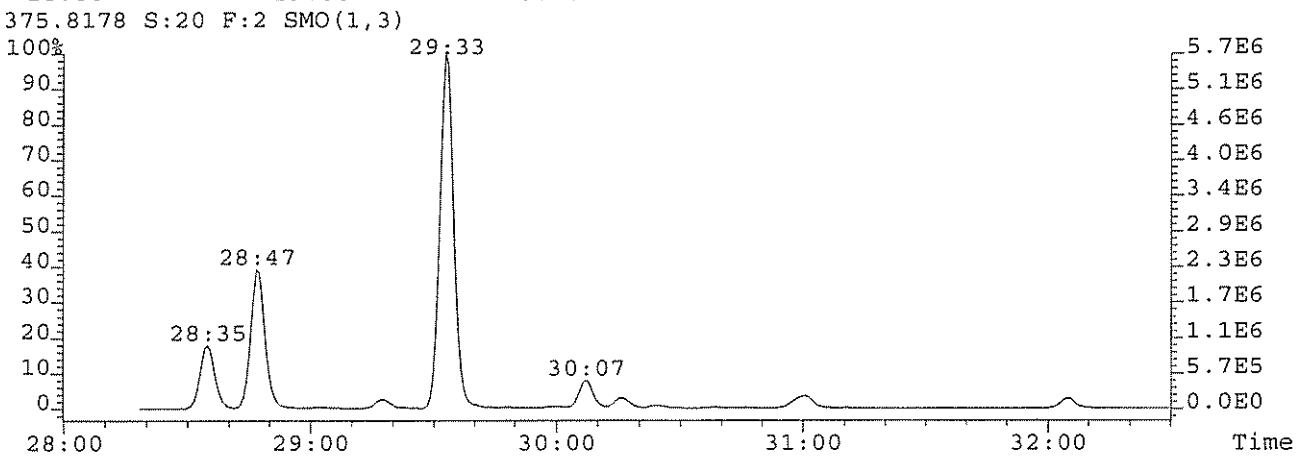
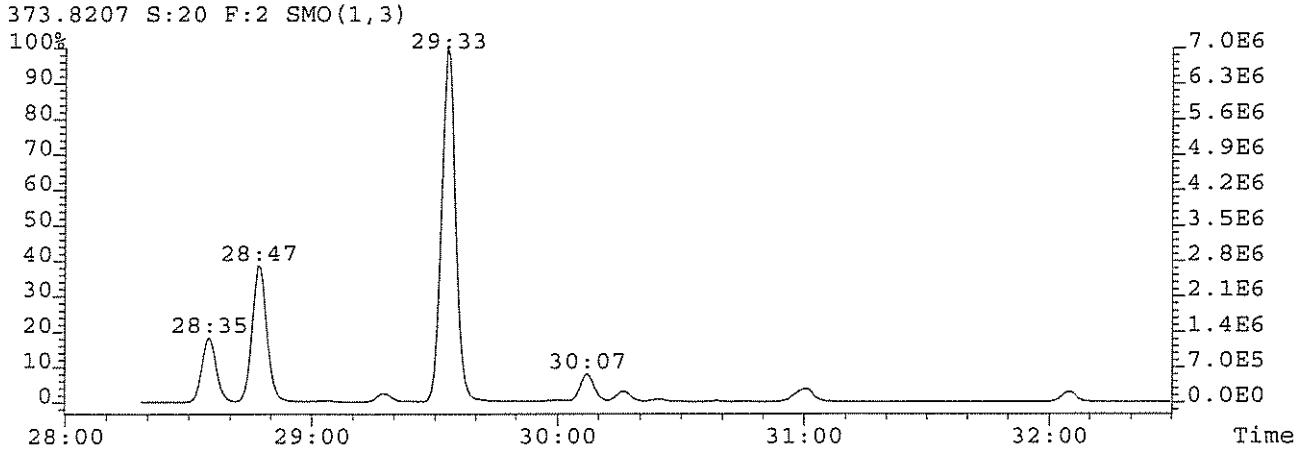


367.8949 S:20 SMO(1,3)



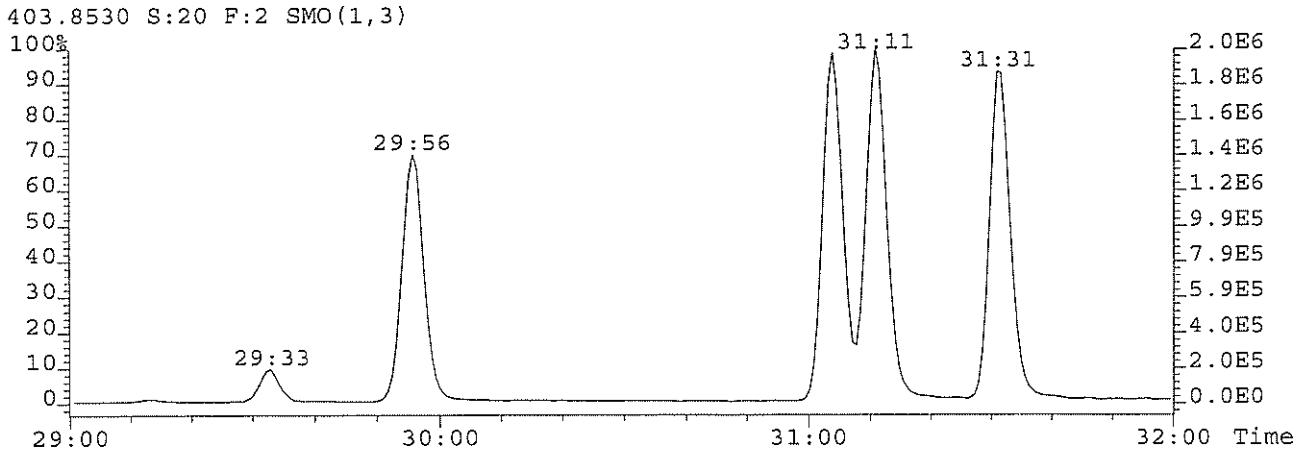
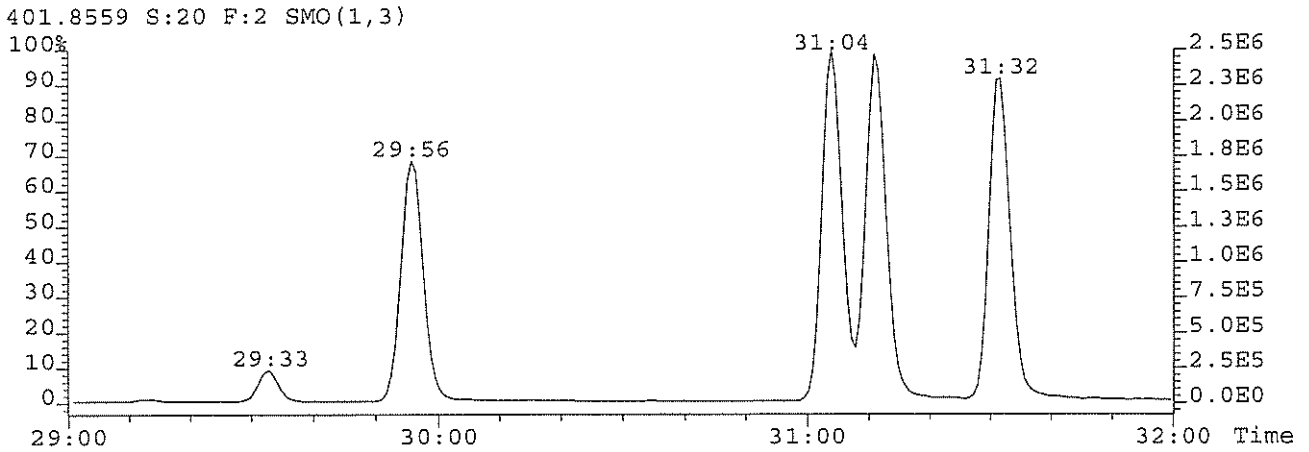
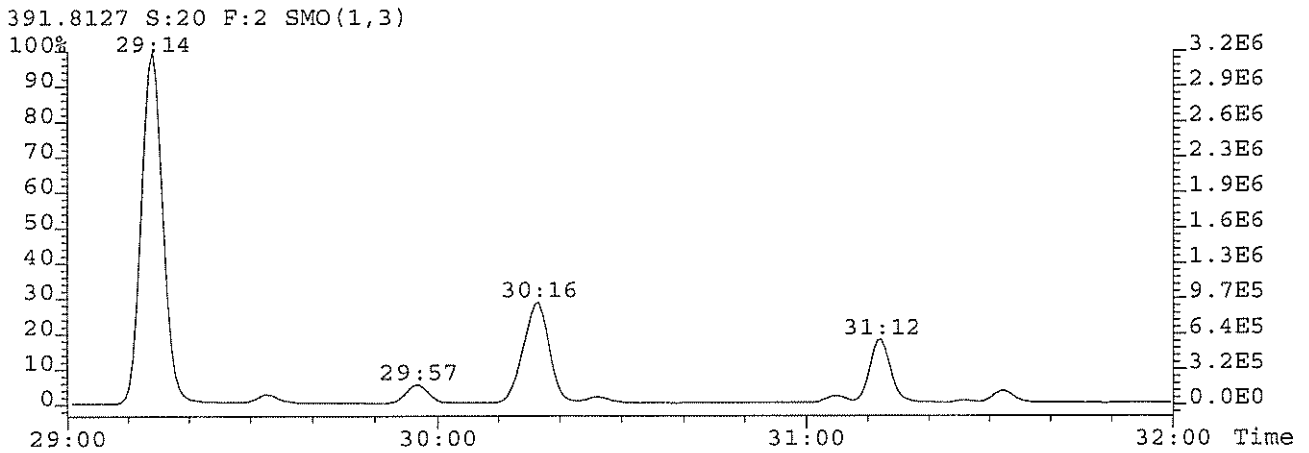
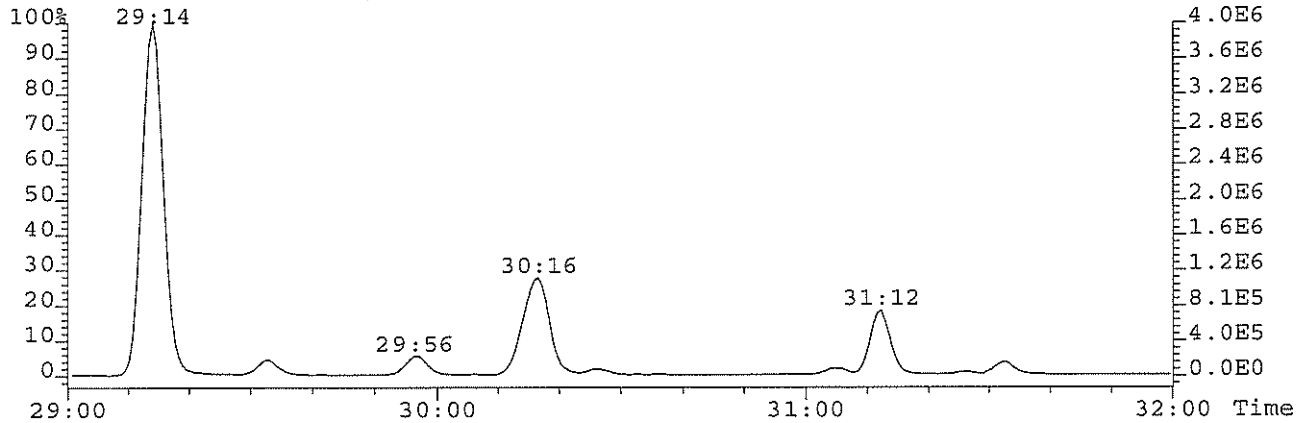
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130712-2 #1-1117 Acq:13-JUL-2013 07:18:15 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:BPX-DXN(4-6DXN) Text:XE13 0963 Exp:BPX04



PCDFsクロマトグラム (5)  
(HxCDFs)

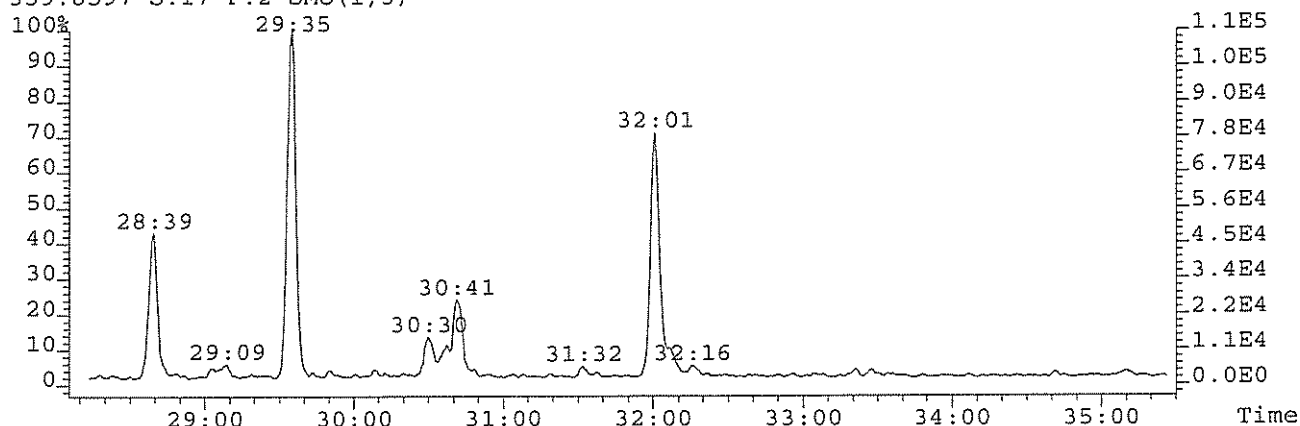
File:130712-2 #1-1117 Acq:13-JUL-2013 07:18:15 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:BPX-DXN(4-6DXN) Text:XE13 0963 Exp:BPX04  
389.8156 S:20 F:2 SMO(1,3)



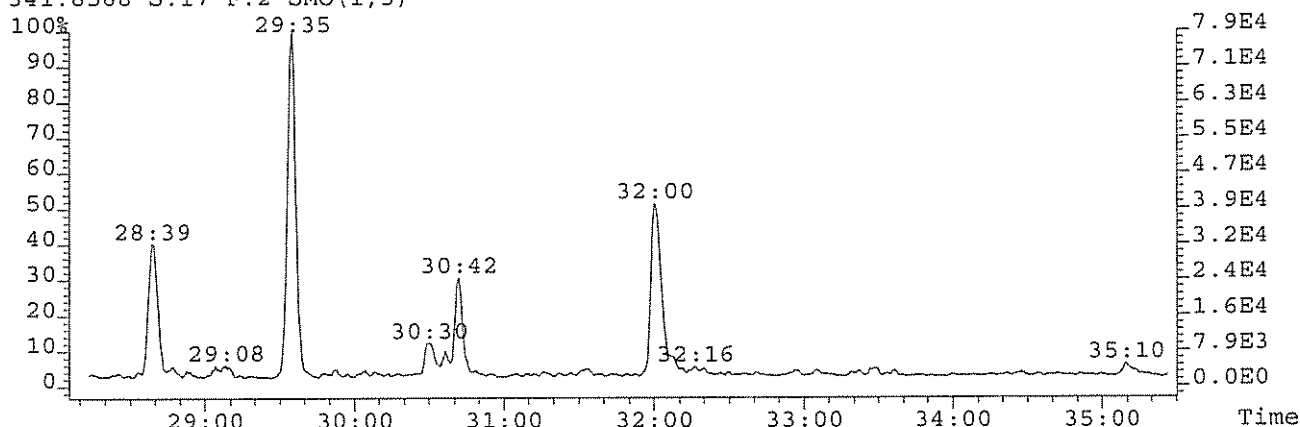
PCDDsクロマトグラム (6)  
(HxCDDs)

File:130713 #1-648 Acq:14-JUL-2013 01:27:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0963 3 Exp:RH-PD22

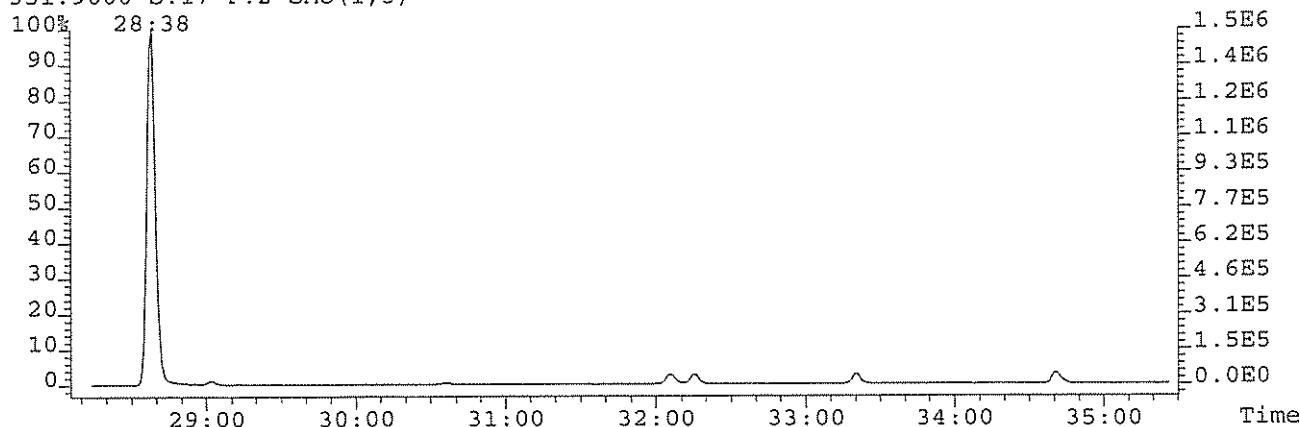
339.8597 S:17 F:2 SMO(1,3)



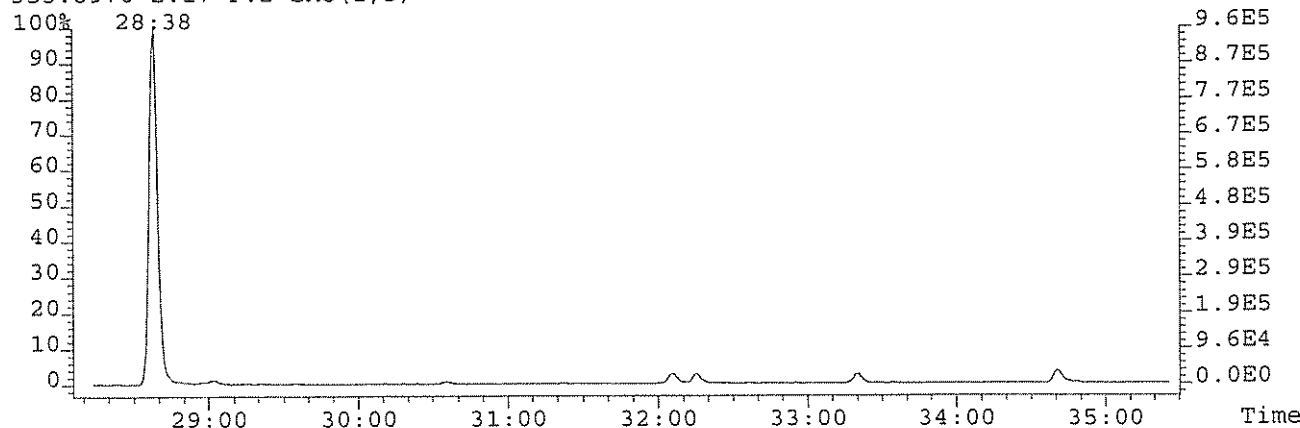
341.8568 S:17 F:2 SMO(1,3)



351.9000 S:17 F:2 SMO(1,3)

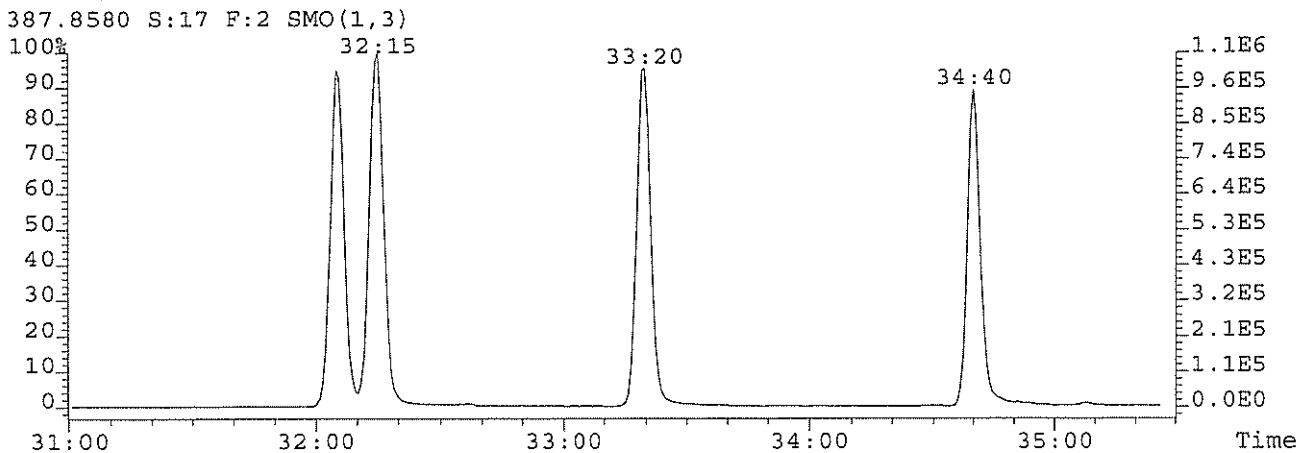
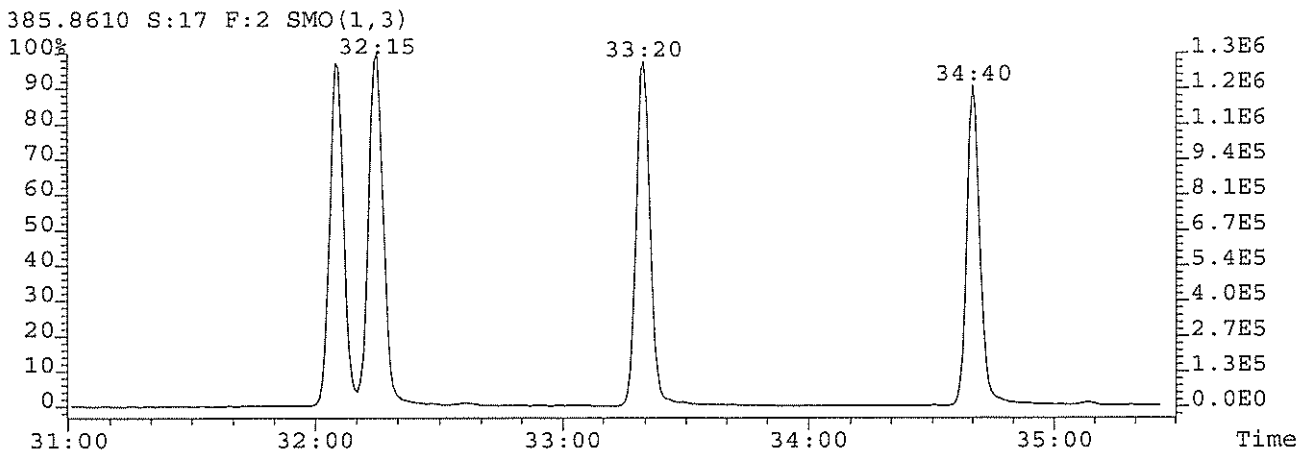
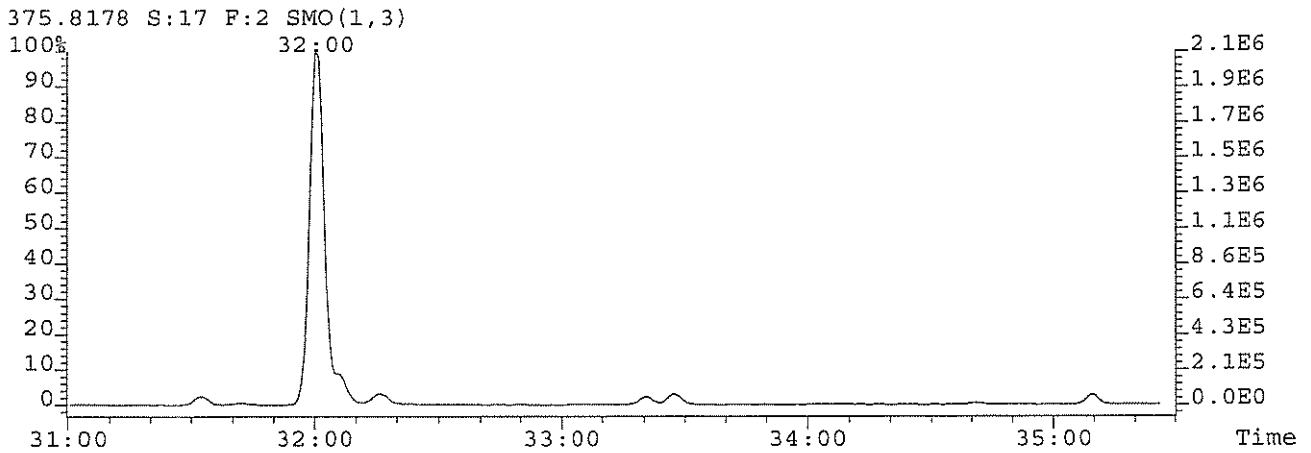
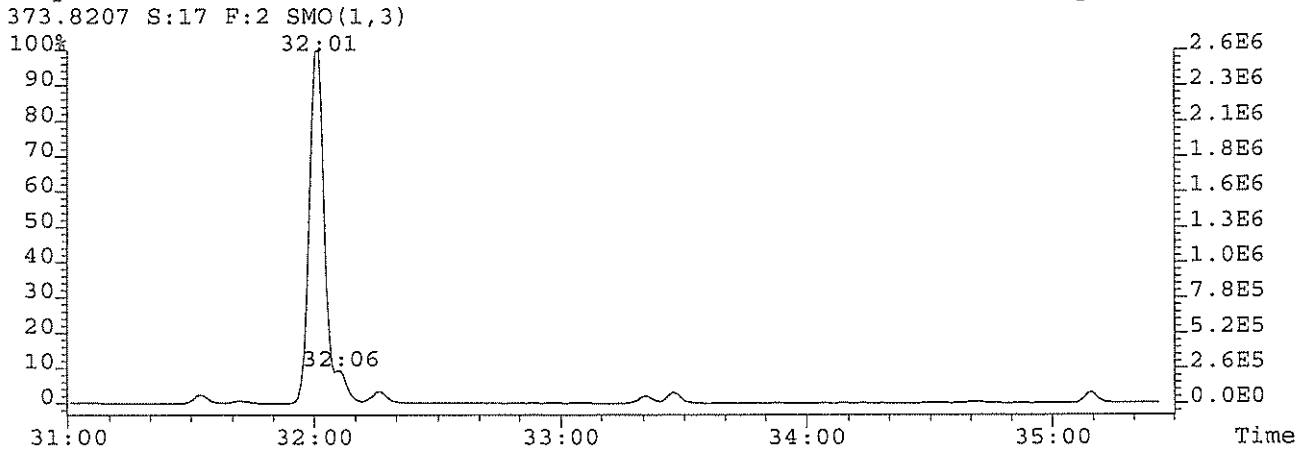


353.8970 S:17 F:2 SMO(1,3)



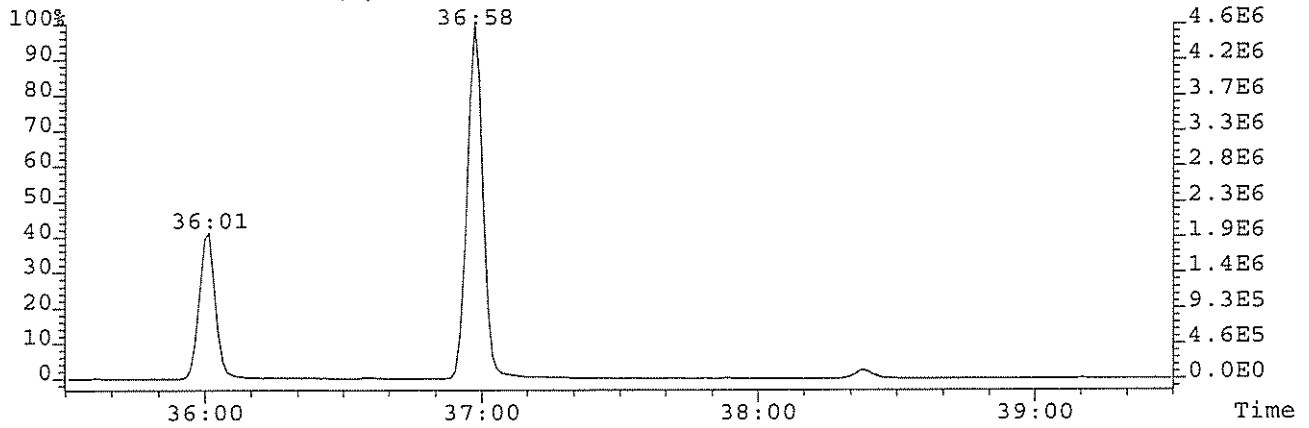
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130713 #1-648 Acq:14-JUL-2013 01:27:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0963 3 Exp:RH-PD22

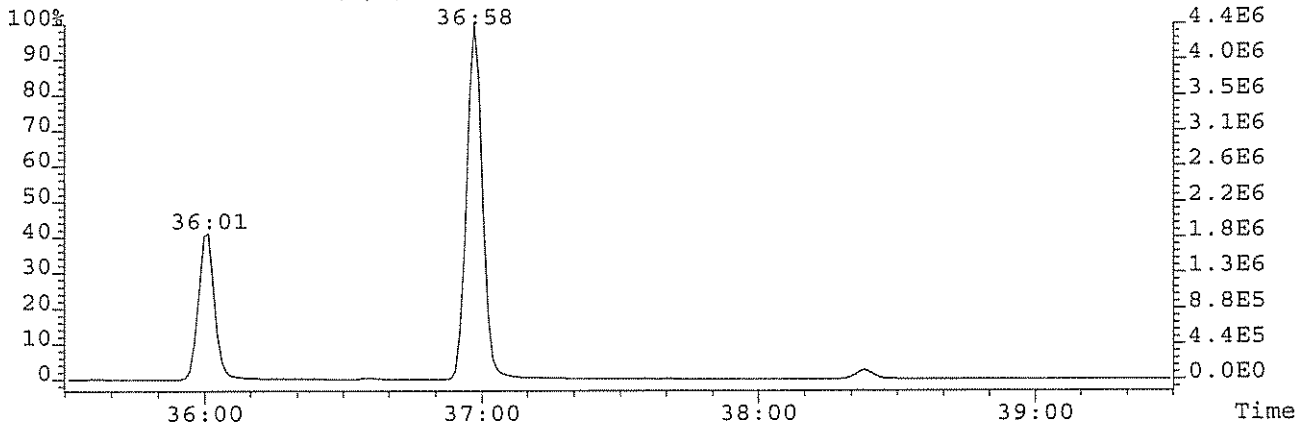


HxCDFsクロマトグラム (8)  
(123789-HxCDF)

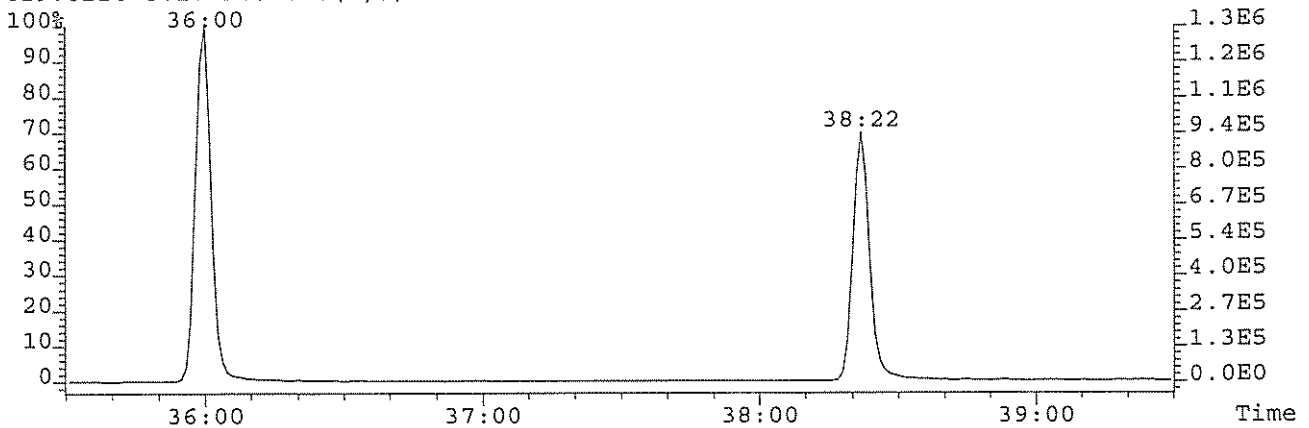
File:130713 #1-562 Acq:14-JUL-2013 01:27:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0963 3 Exp:RH-PD22  
407.7818 S:17 F:3 SMO(1,3)



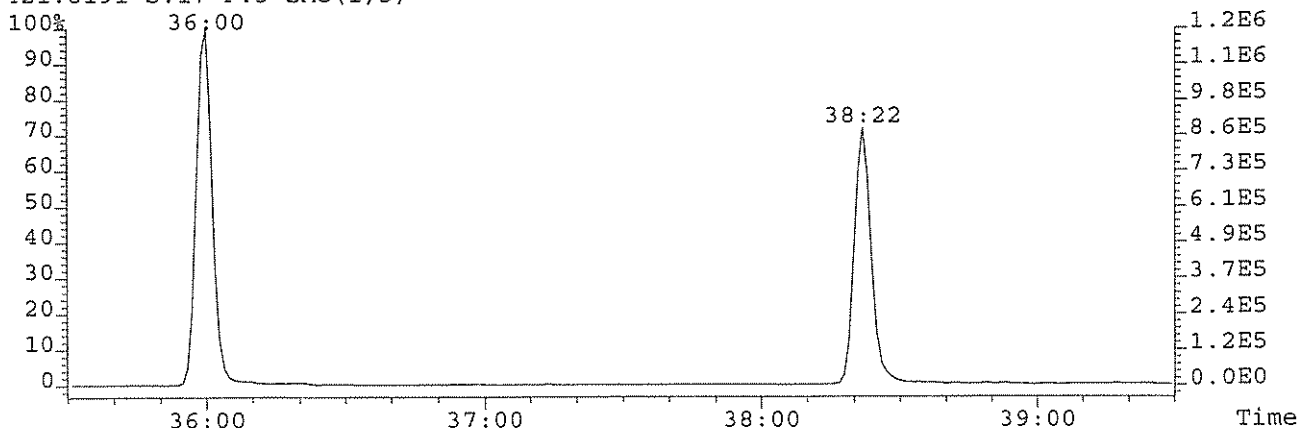
409.7788 S:17 F:3 SMO(1,3)



419.8220 S:17 F:3 SMO(1,3)



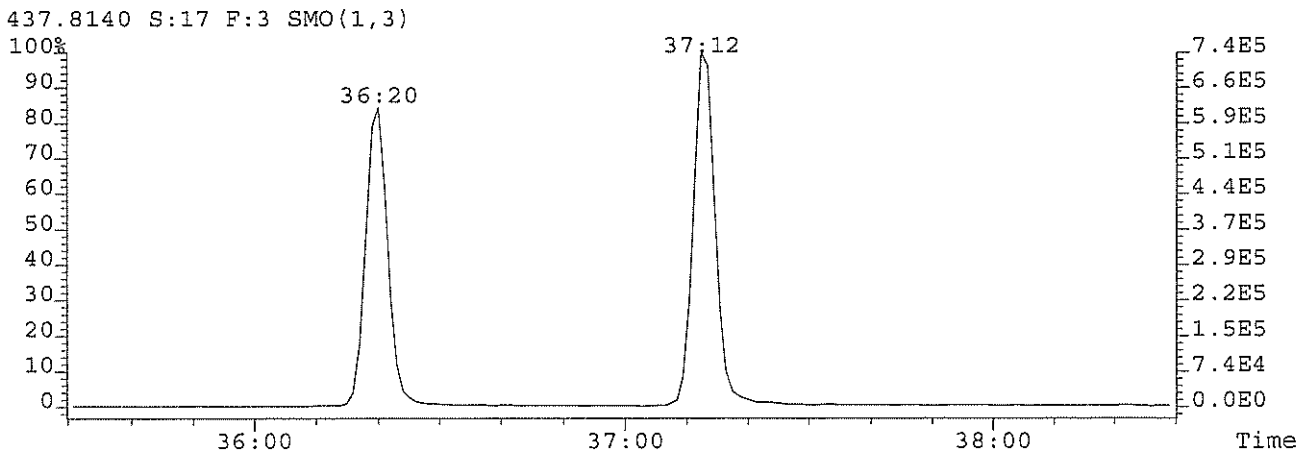
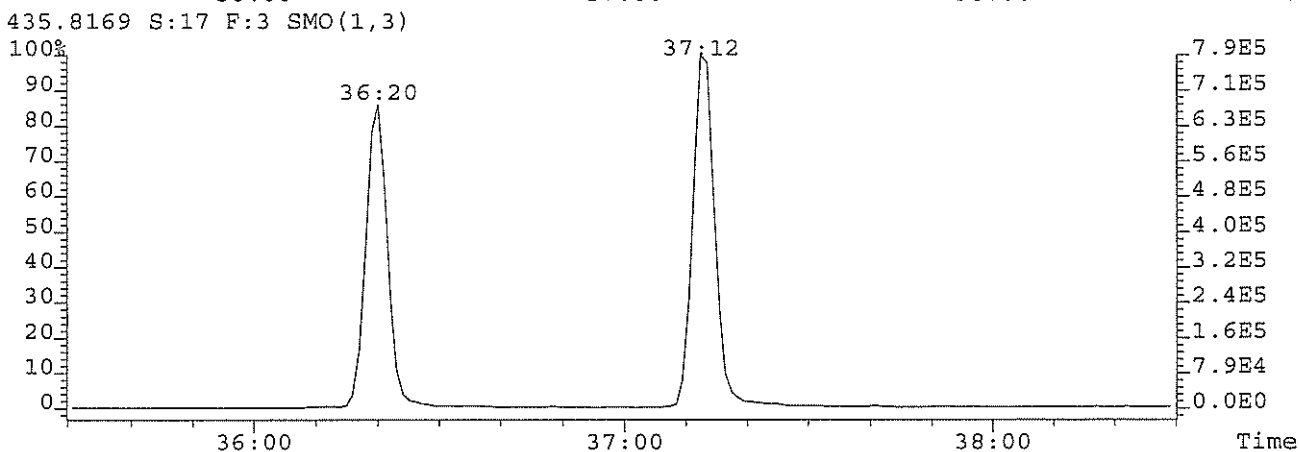
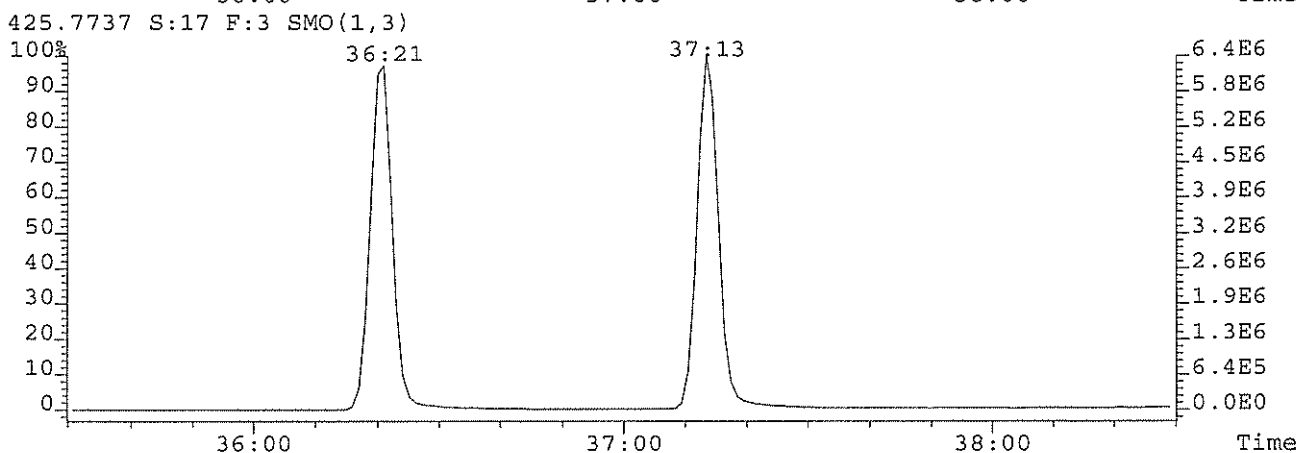
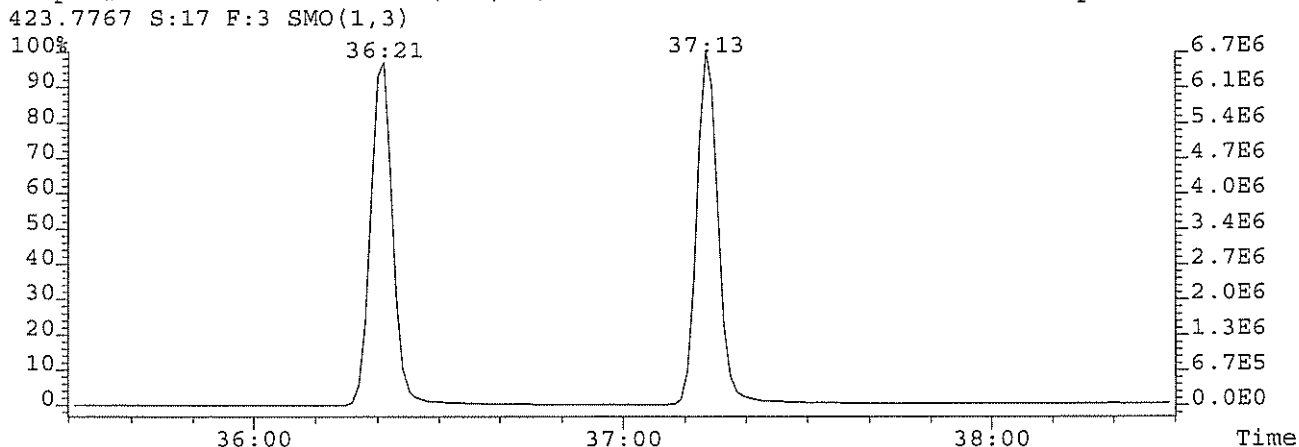
421.8191 S:17 F:3 SMO(1,3)



PCDFsクロマトグラム (9)  
(HpCDFs)



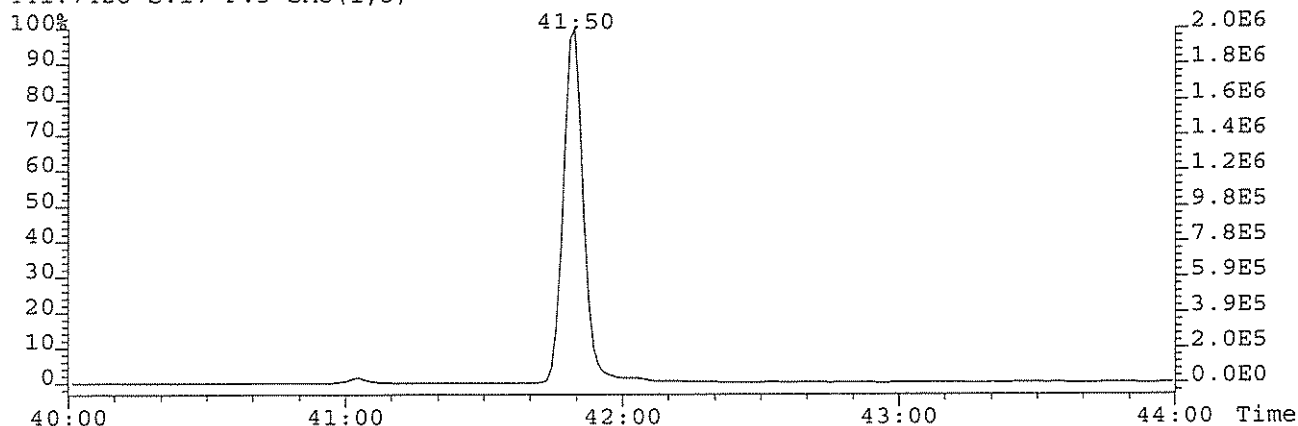
File:130713 #1-562 Acq:14-JUL-2013 01:27:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0963 3 Exp:RH-PD22



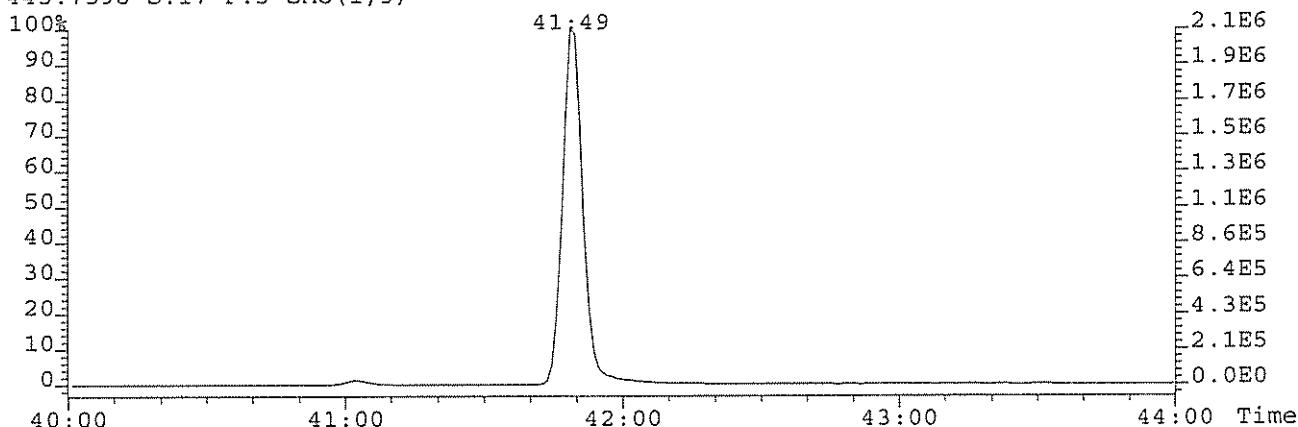
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130713 #1-562 Acq:14-JUL-2013 01:27:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0963 3 Exp:RH-PD22

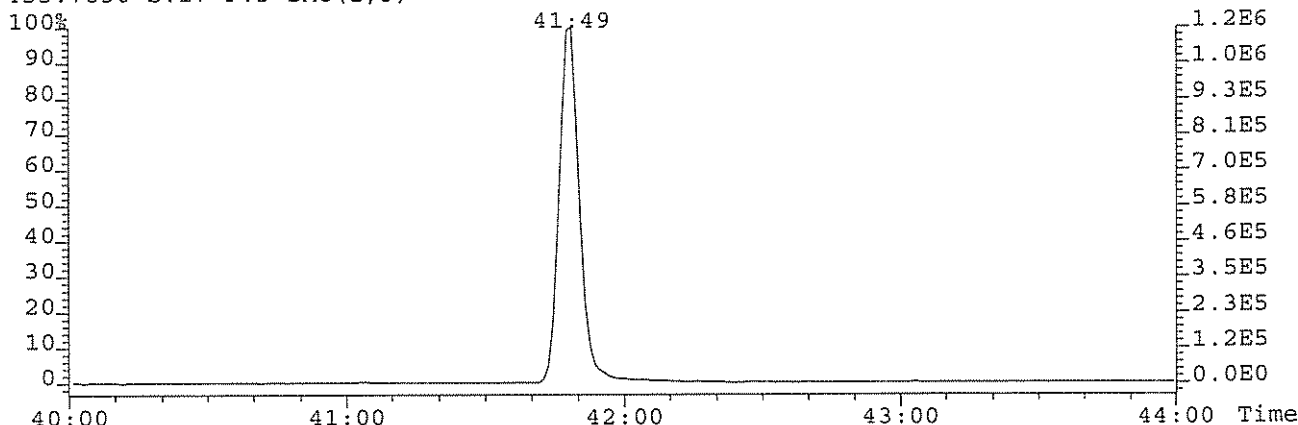
441.7428 S:17 F:3 SMO(1,3)



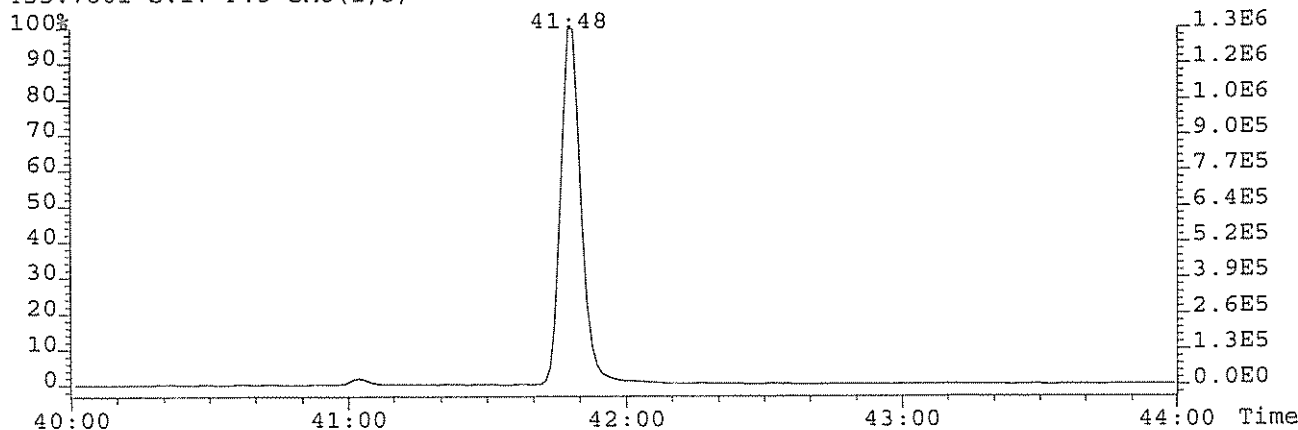
443.7398 S:17 F:3 SMO(1,3)



453.7830 S:17 F:3 SMO(1,3)

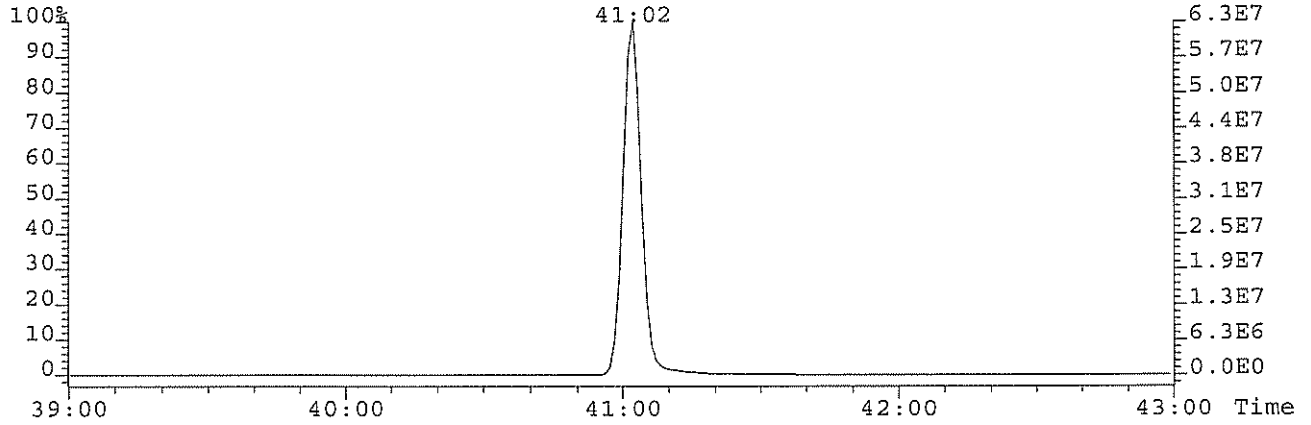


455.7801 S:17 F:3 SMO(1,3)

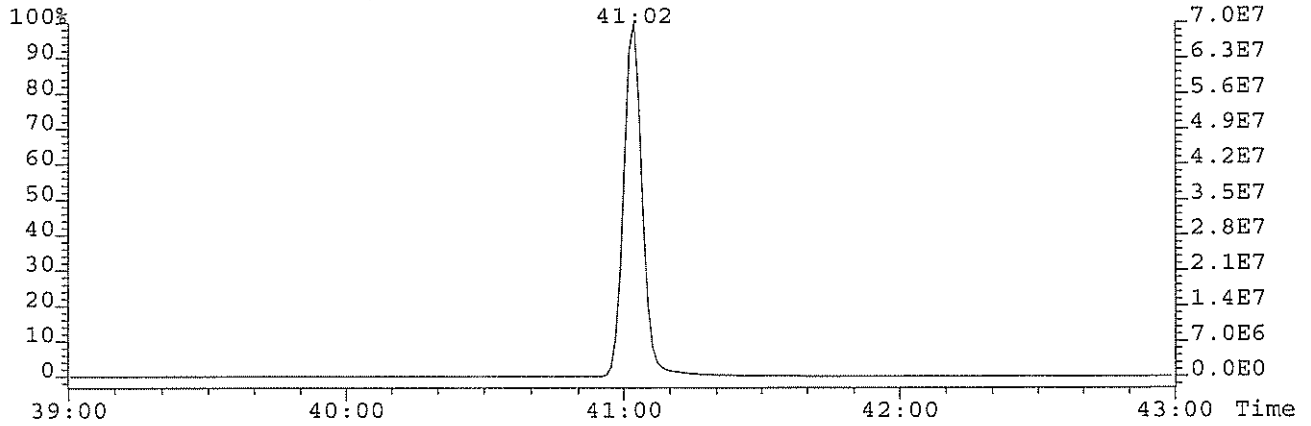


PCDFsクロマトグラム (11)  
(OCDF)

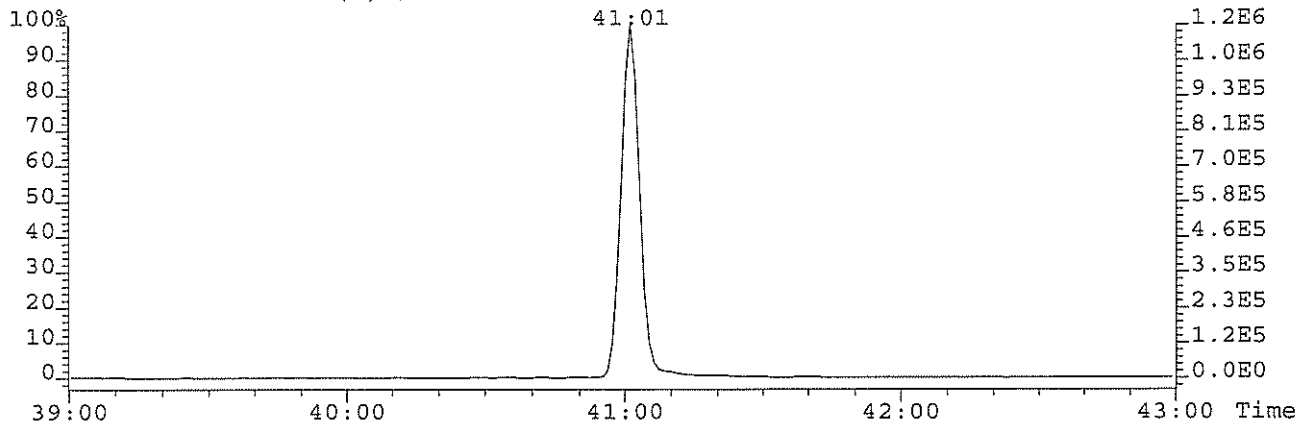
File:130713 #1-562 Acq:14-JUL-2013 01:27:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0963 3 Exp:RH-PD22  
457.7377 S:17 F:3 SMO(1,3)



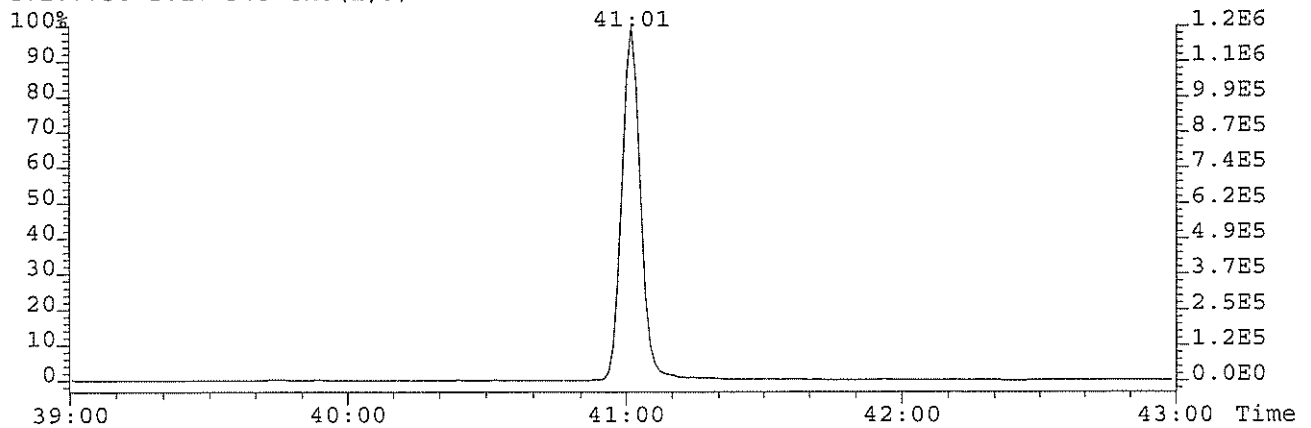
459.7348 S:17 F:3 SMO(1,3)



469.7780 S:17 F:3 SMO(1,3)

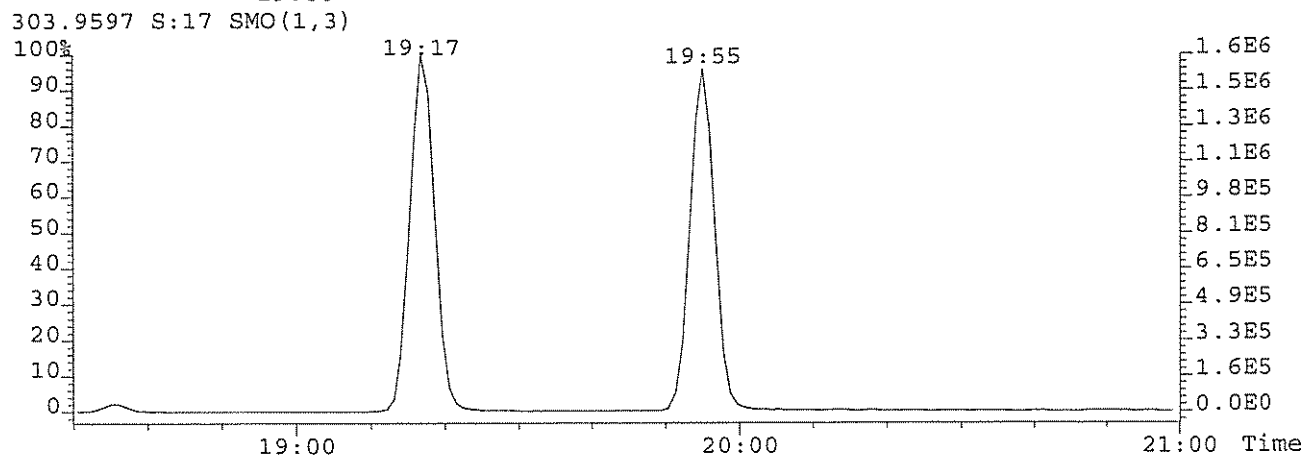
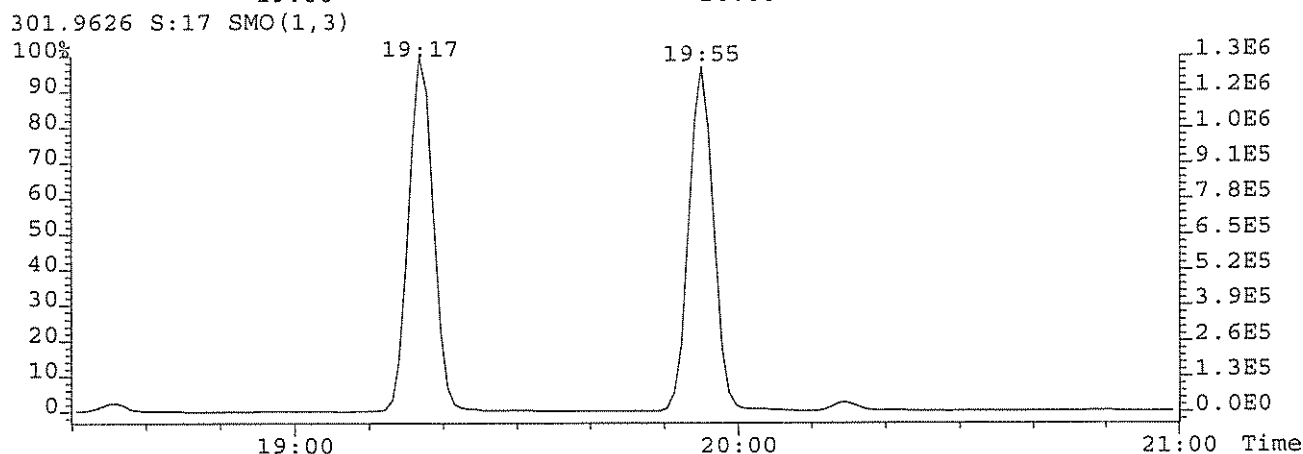
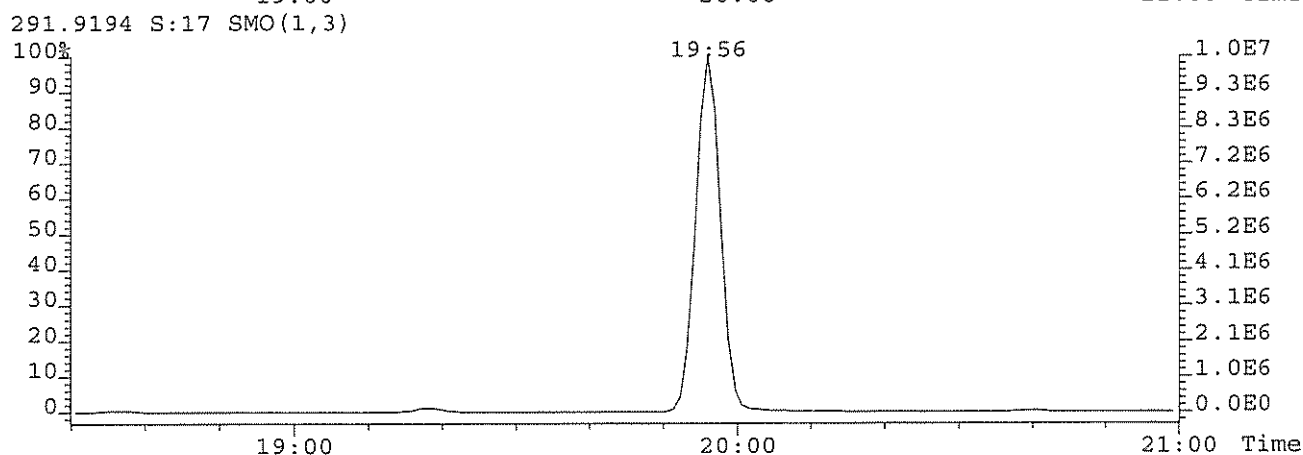
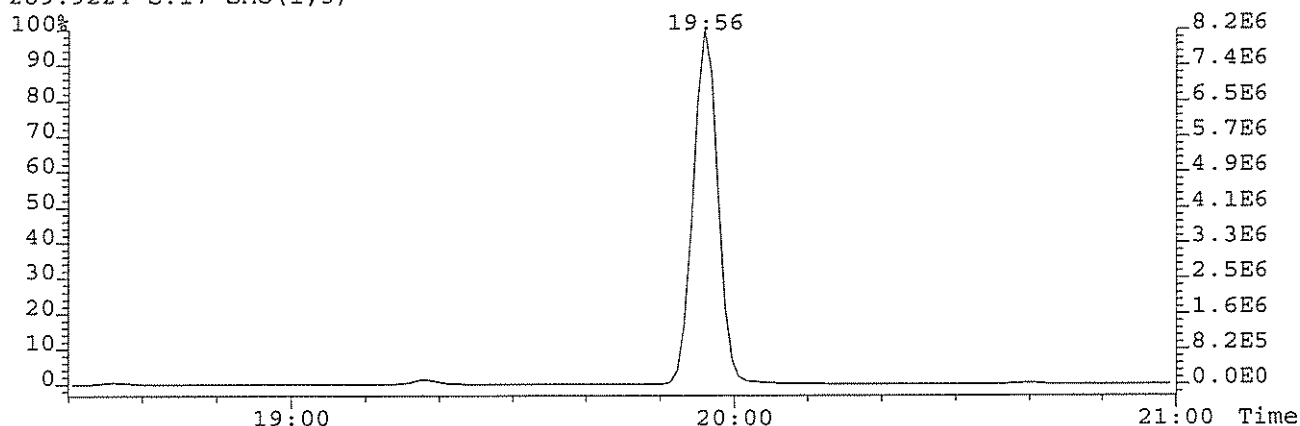


471.7750 S:17 F:3 SMO(1,3)



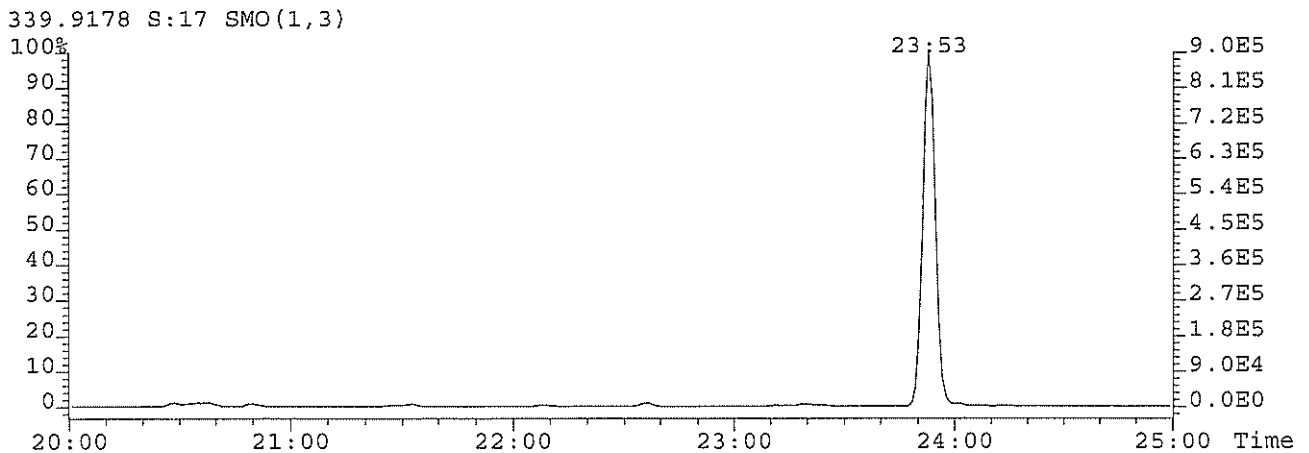
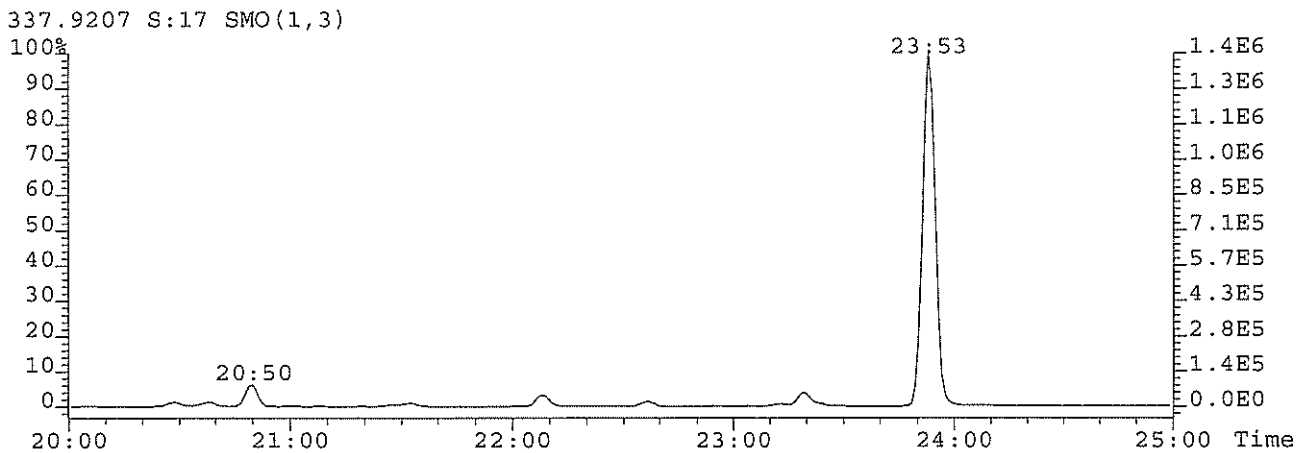
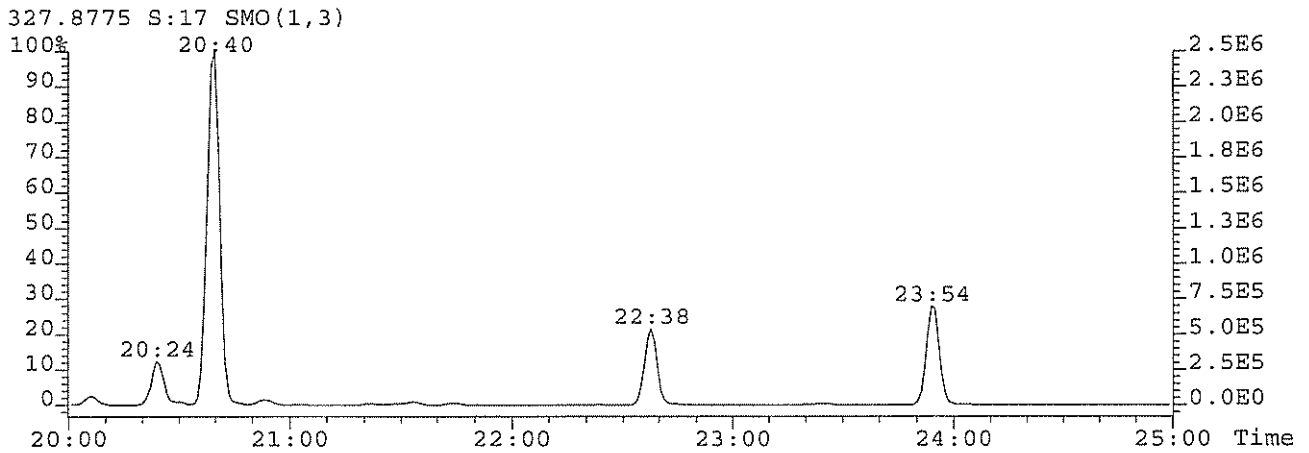
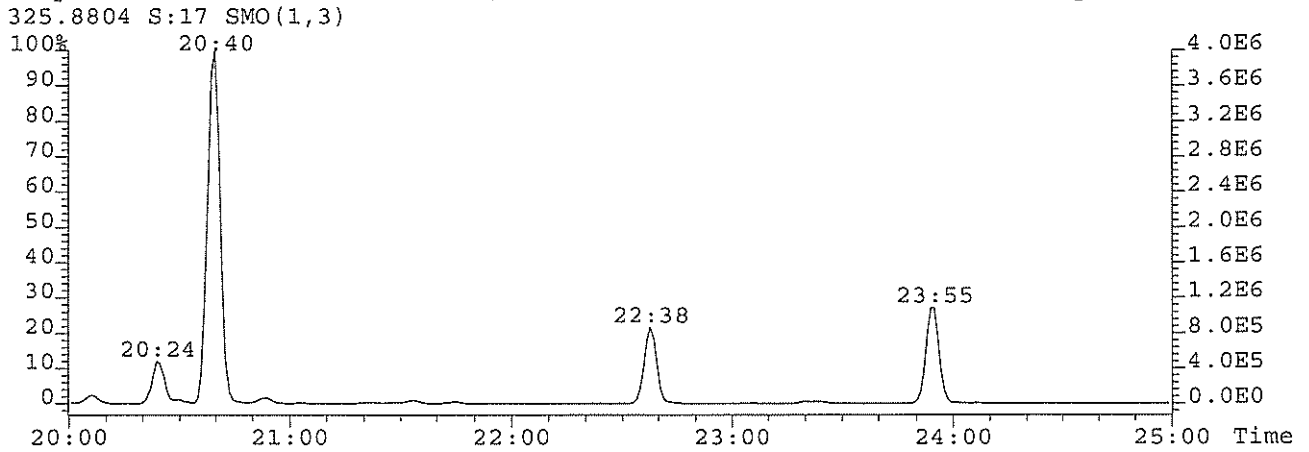
PCDDsクロマトグラム (12)  
(OCDD)

File:130713 #1-1430 Acq:14-JUL-2013 01:27:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0963 3 Exp:RH-PD22  
289.9224 S:17 SMO(1,3)



DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

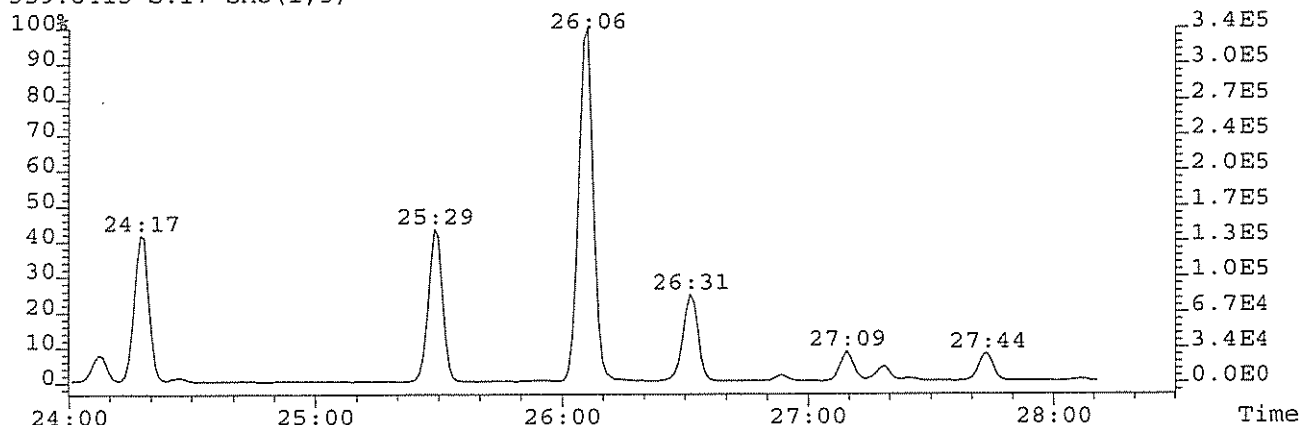
File:130713 #1-1430 Acq:14-JUL-2013 01:27:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0963 3 Exp:RH-PD22



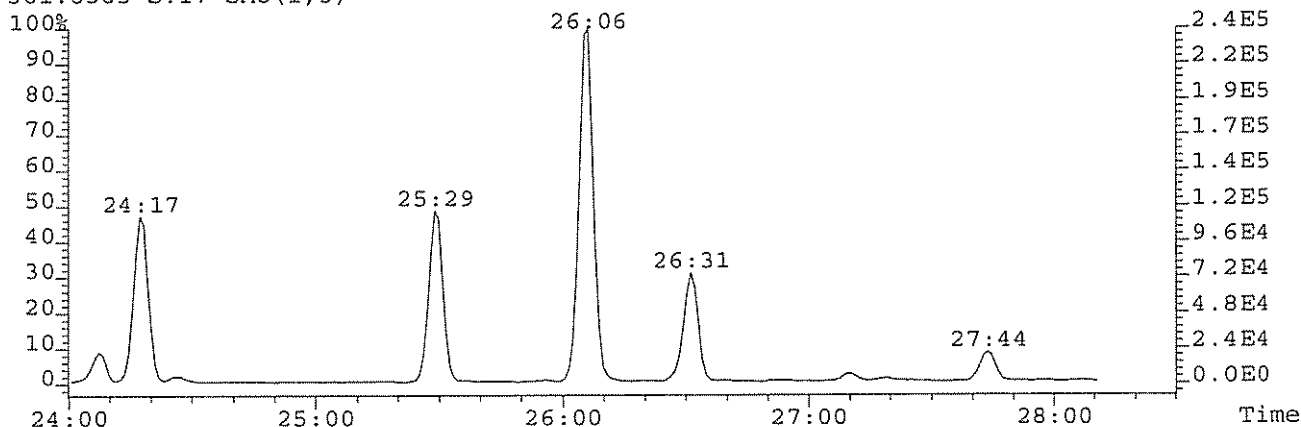
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130713 #1-1430 Acq:14-JUL-2013 01:27:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#17 File Text:RH-12ms(5-8,nP) Text:XE13 0963 3 Exp:RH-PD22

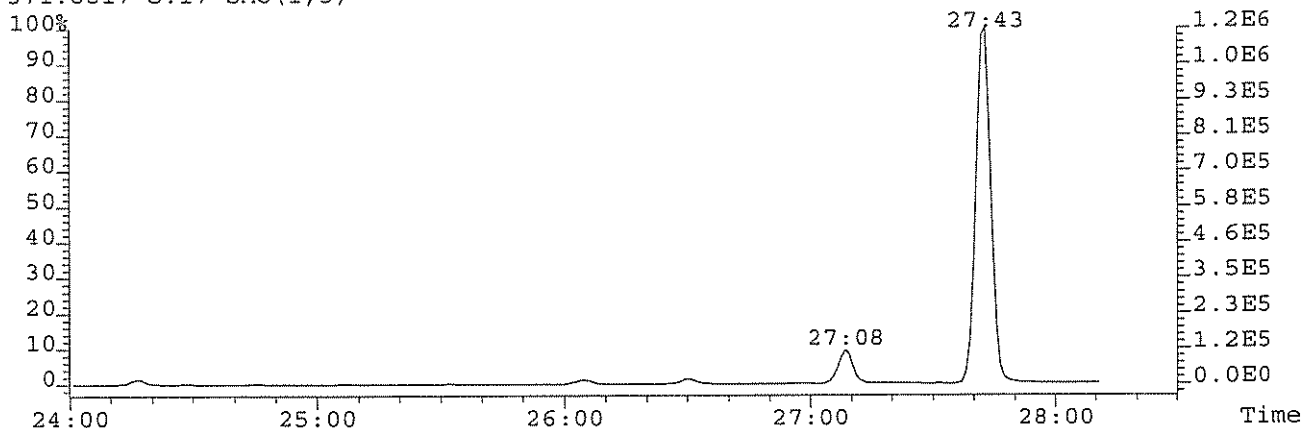
359.8415 S:17 SMO(1,3)



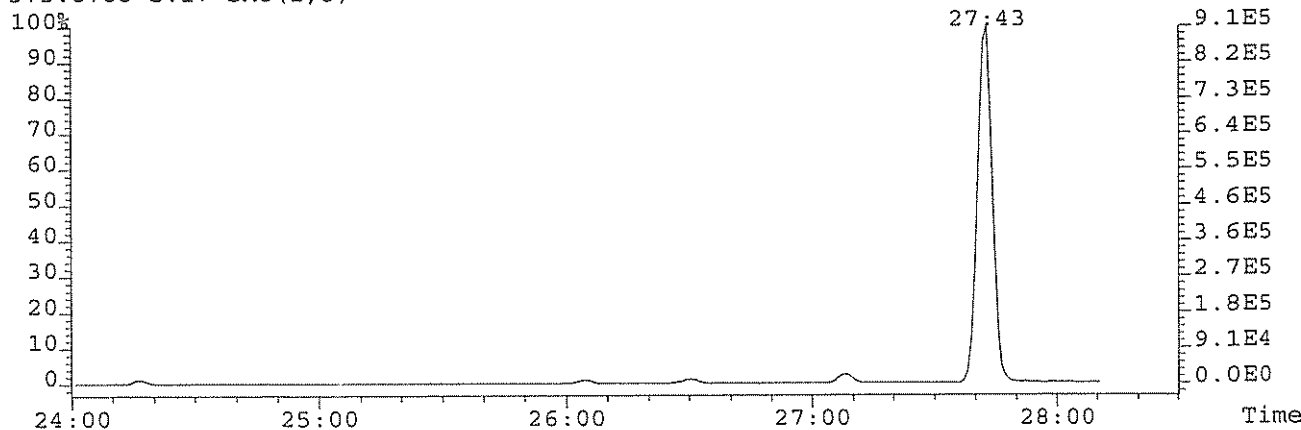
361.8385 S:17 SMO(1,3)



371.8817 S:17 SMO(1,3)

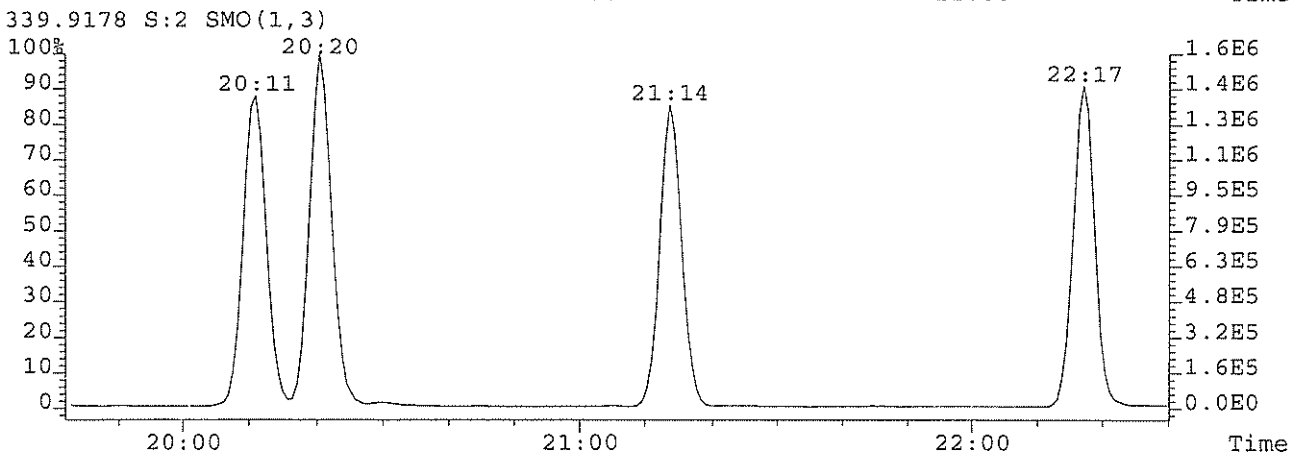
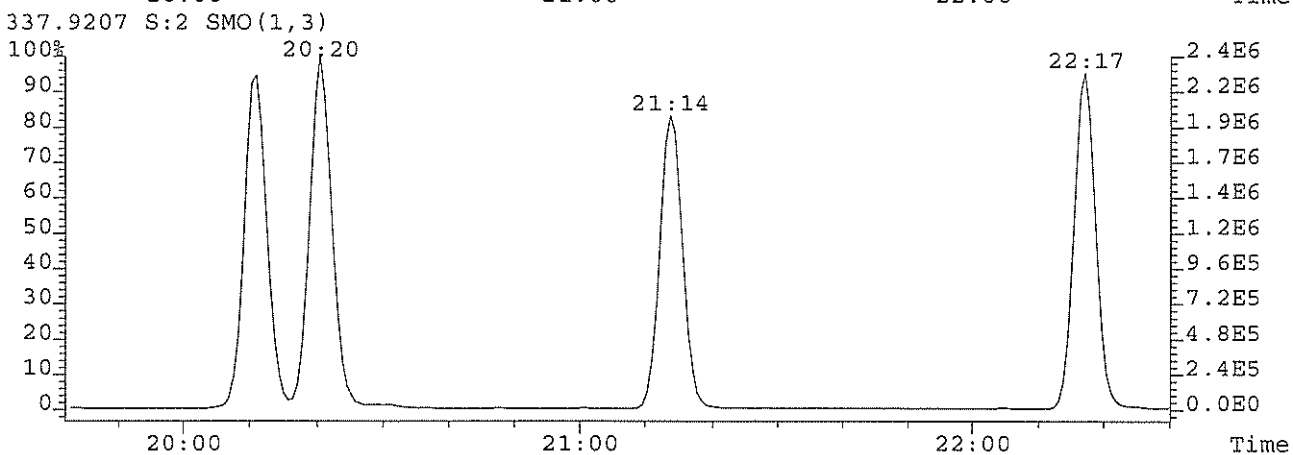
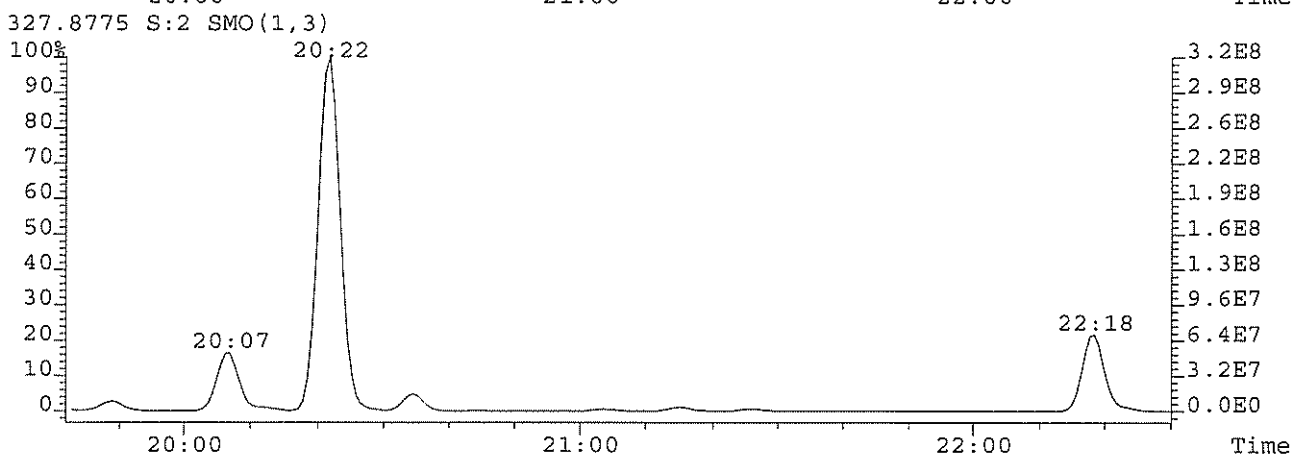
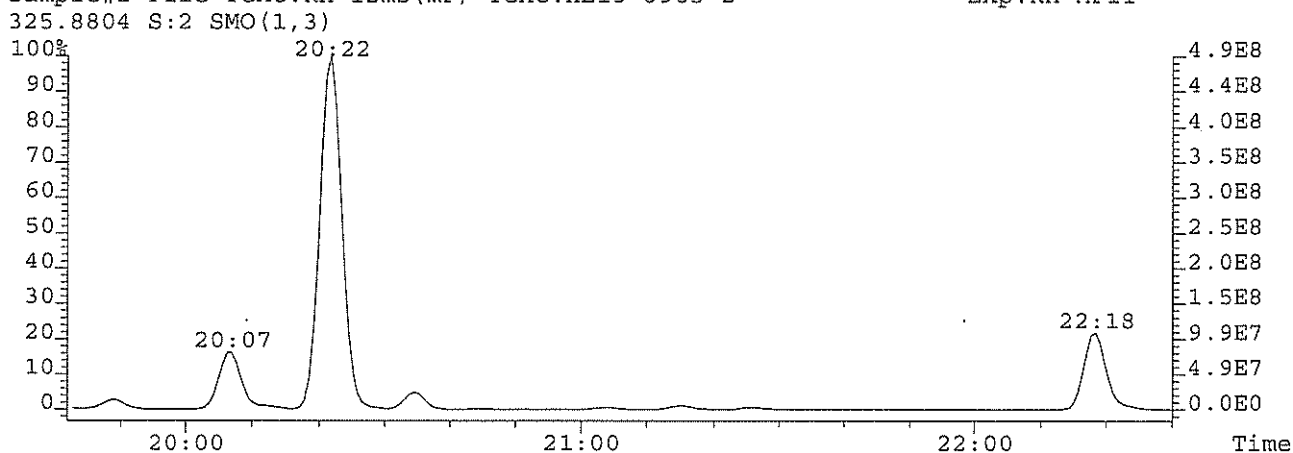


373.8788 S:17 SMO(1,3)



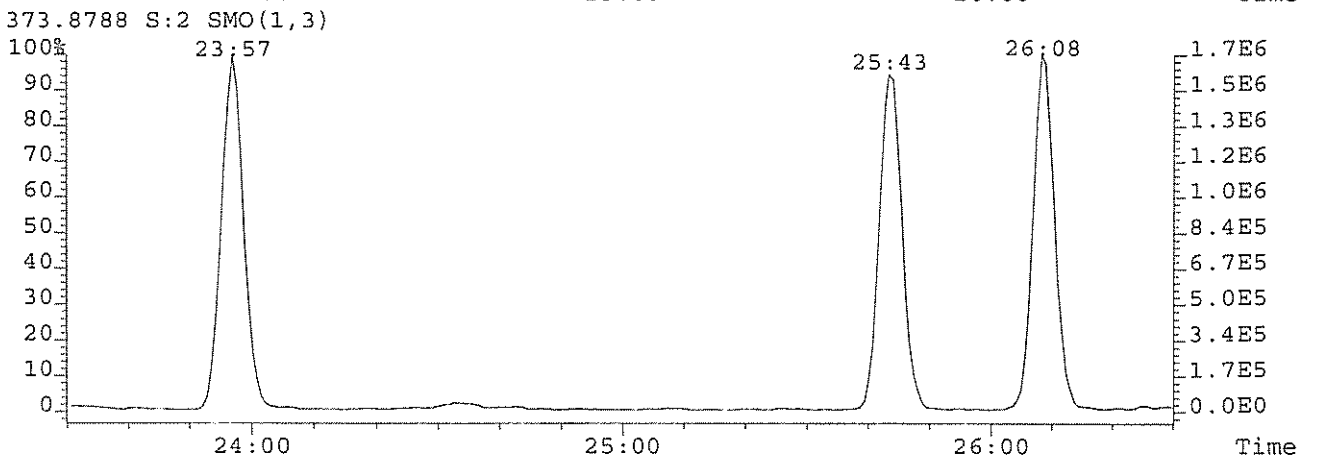
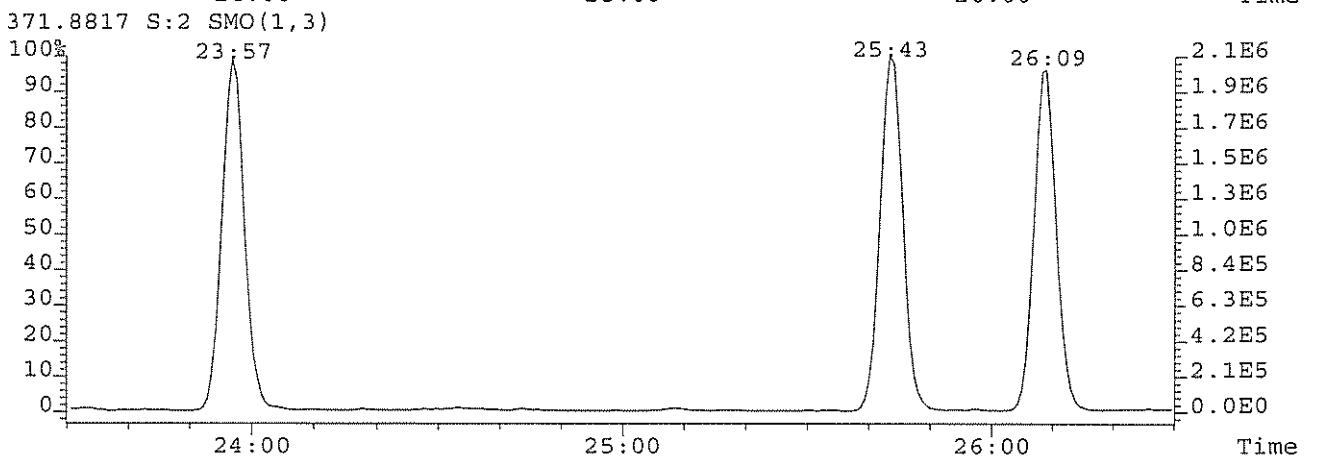
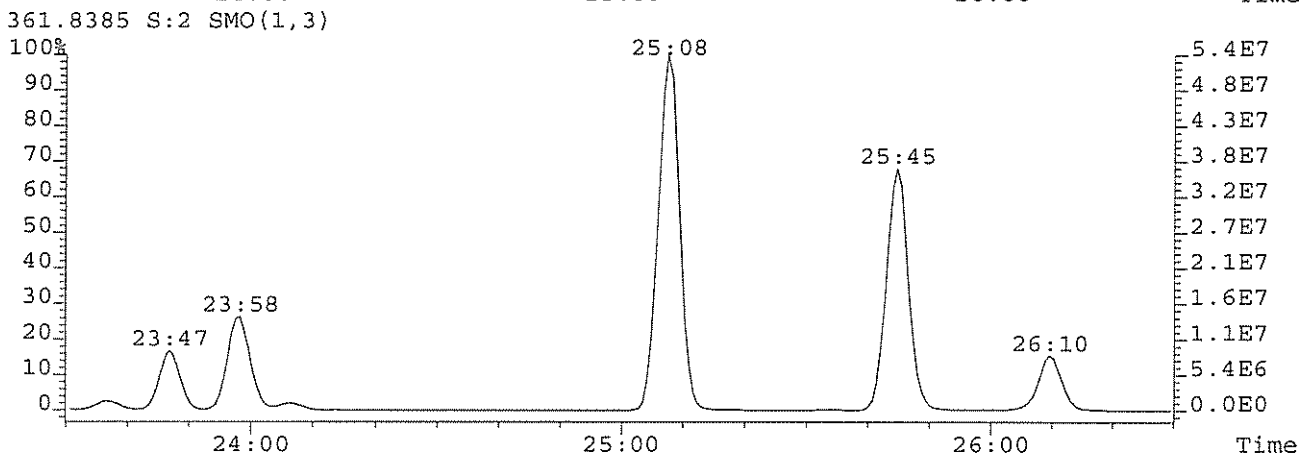
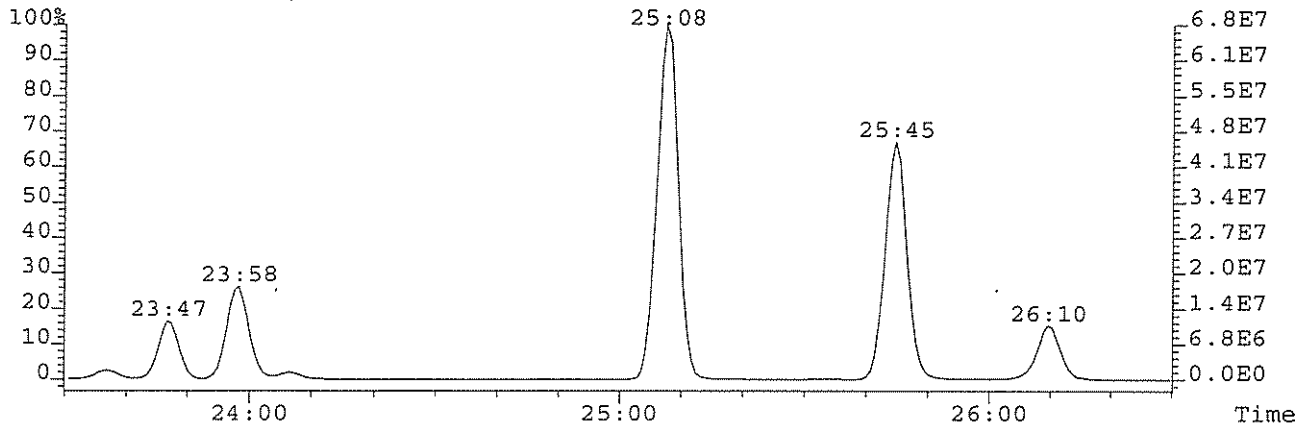
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130716-2 #1-2899 Acq:16-JUL-2013 15:16:46 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:XE13 0963 2 Exp:RH-MP11



DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

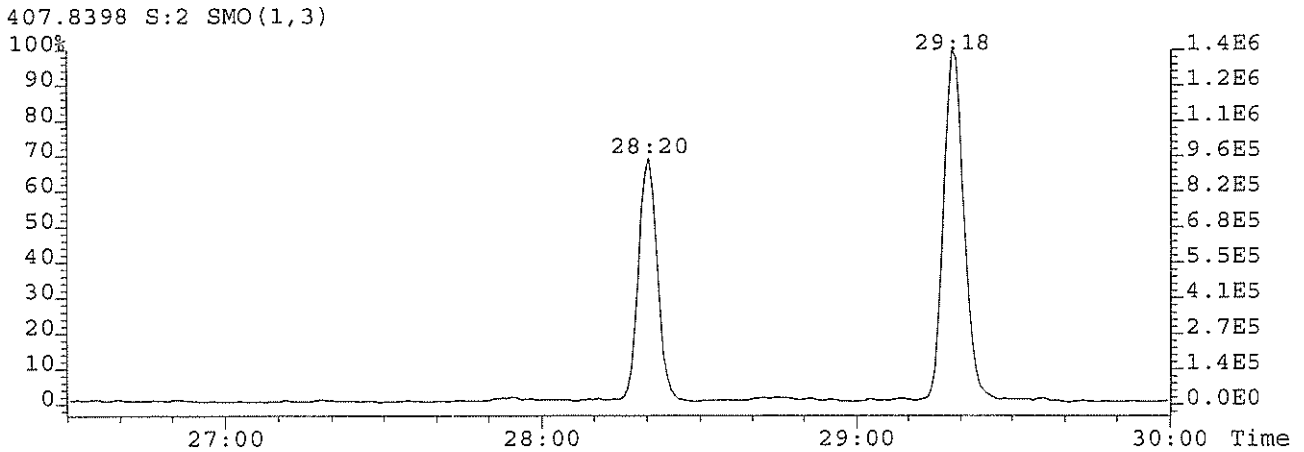
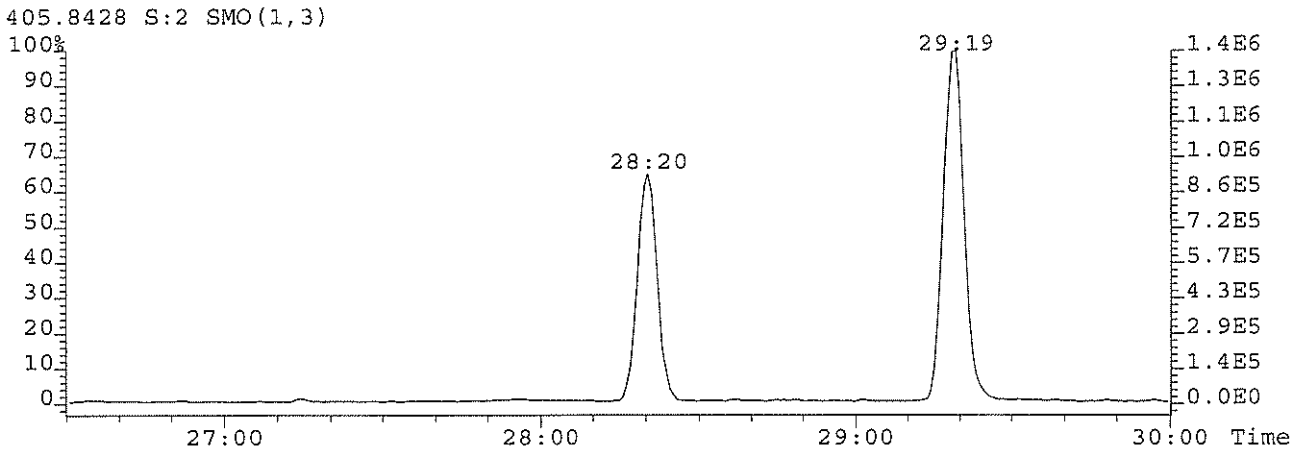
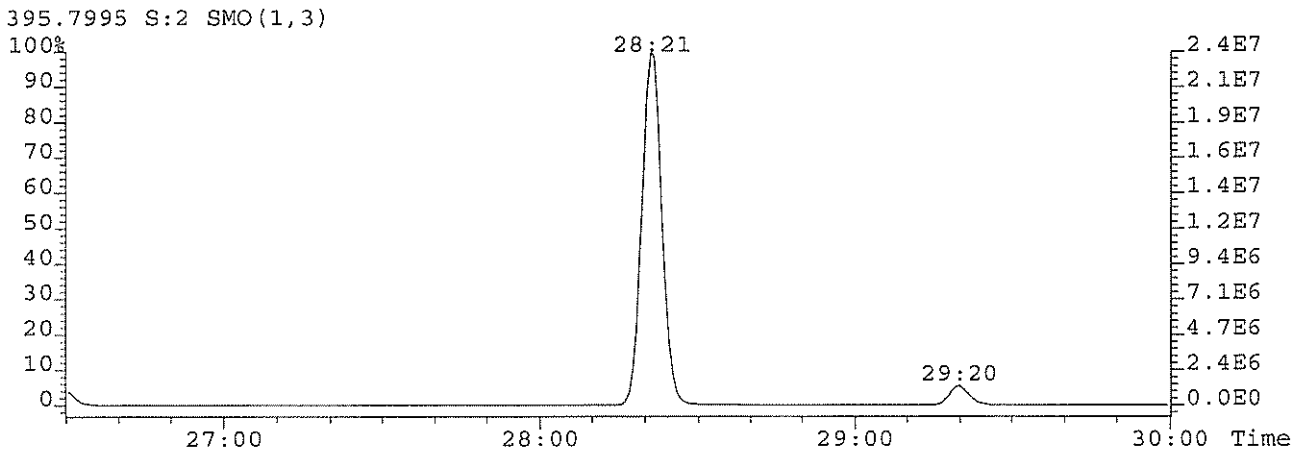
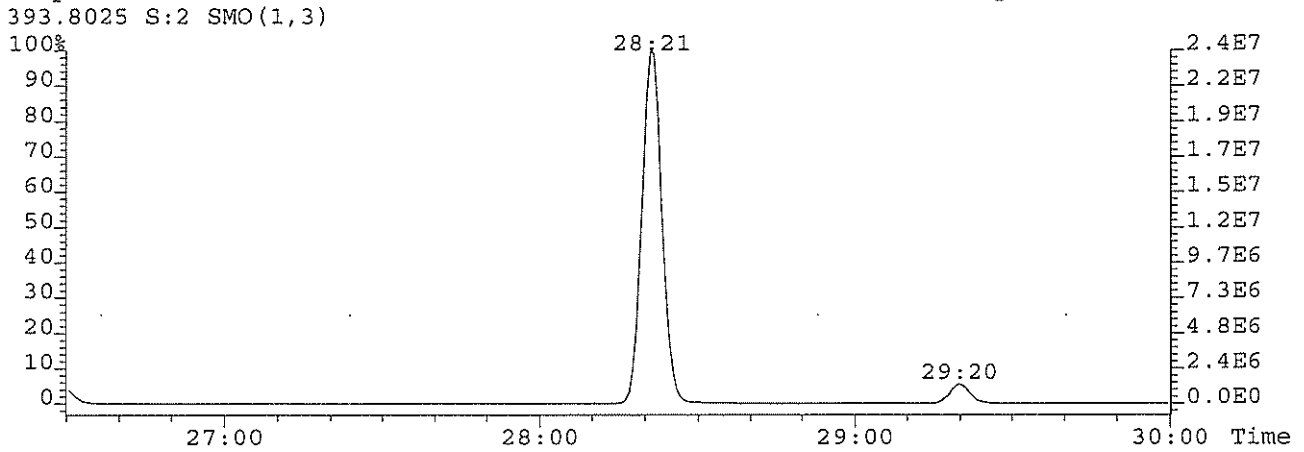
File:130716-2 #1-2899 Acq:16-JUL-2013 15:16:46 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:XE13 0963 2 Exp:RH-MP11  
359.8415 S:2 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)



File:130716-2 #1-2899 Acq:16-JUL-2013 15:16:46 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#2 File Text:RH-12ms(mP) Text:XE13 0963 2 Exp:RH-MP11

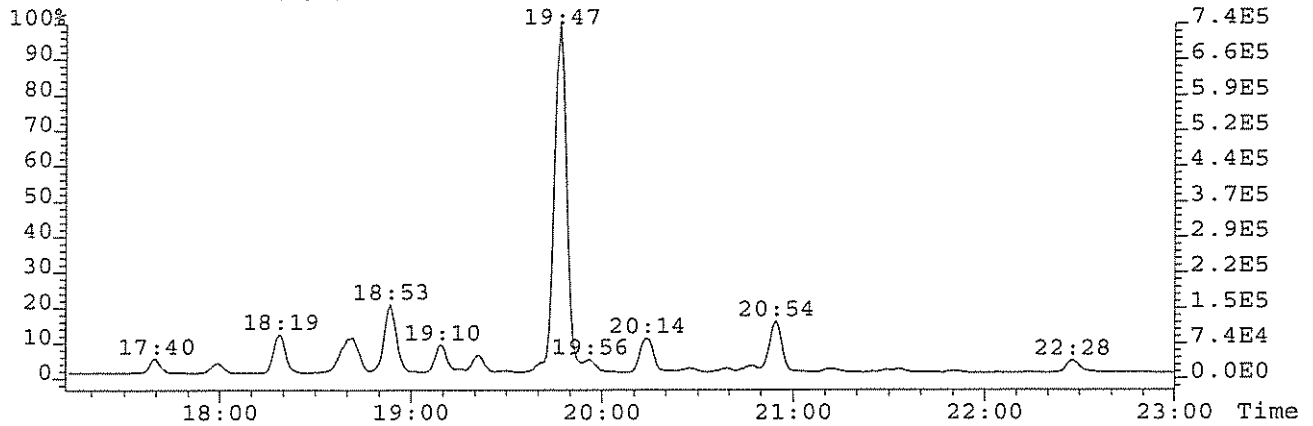


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

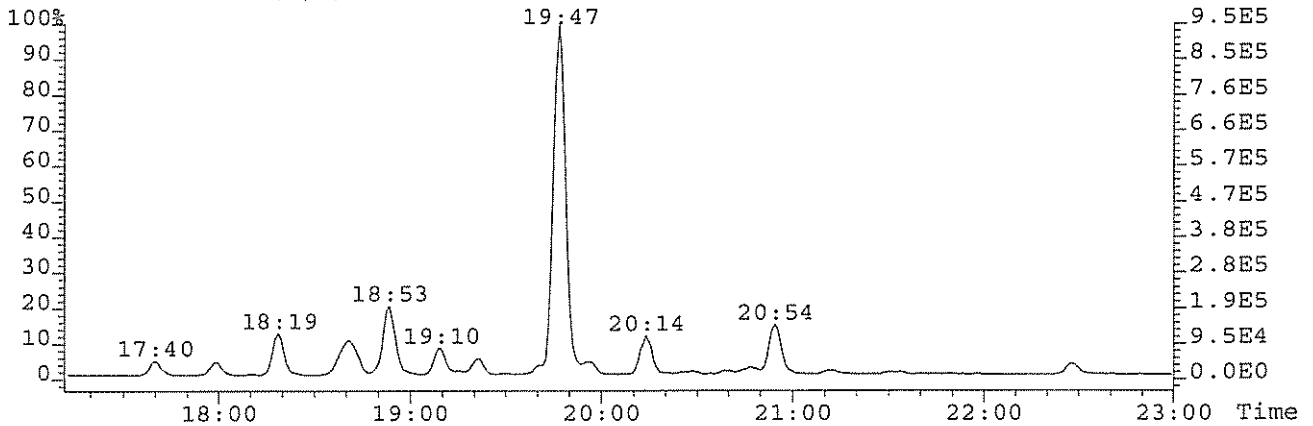
試料管理番号	XE 130964
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.18

File:130712-2 #1-1578 Acq:13-JUL-2013 08:02:25 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:BPX-DXN(4-6DXN) Text:XE13 0964 Exp:BPX04

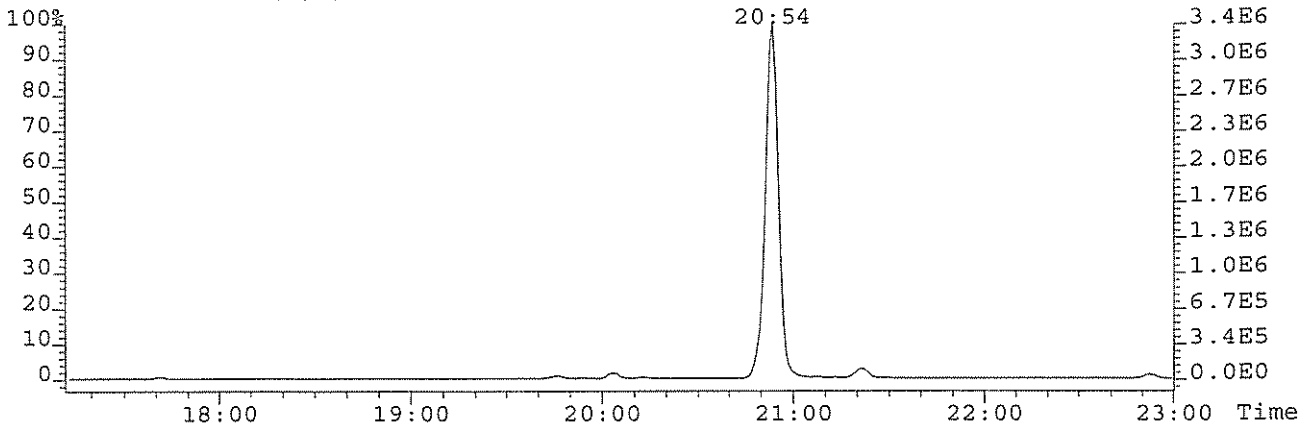
303.9016 S:21 SMO(1,3)



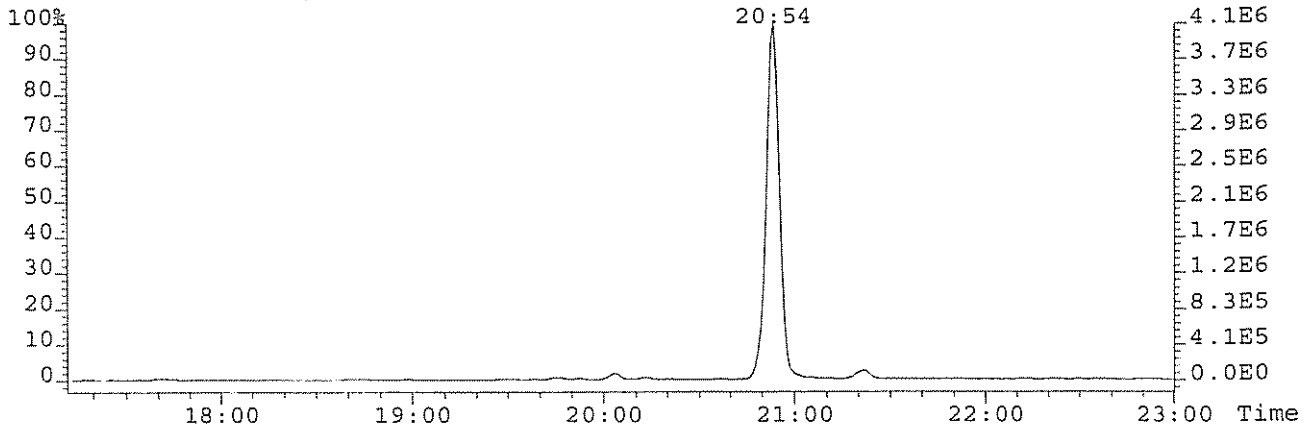
305.8987 S:21 SMO(1,3)



315.9419 S:21 SMO(1,3)

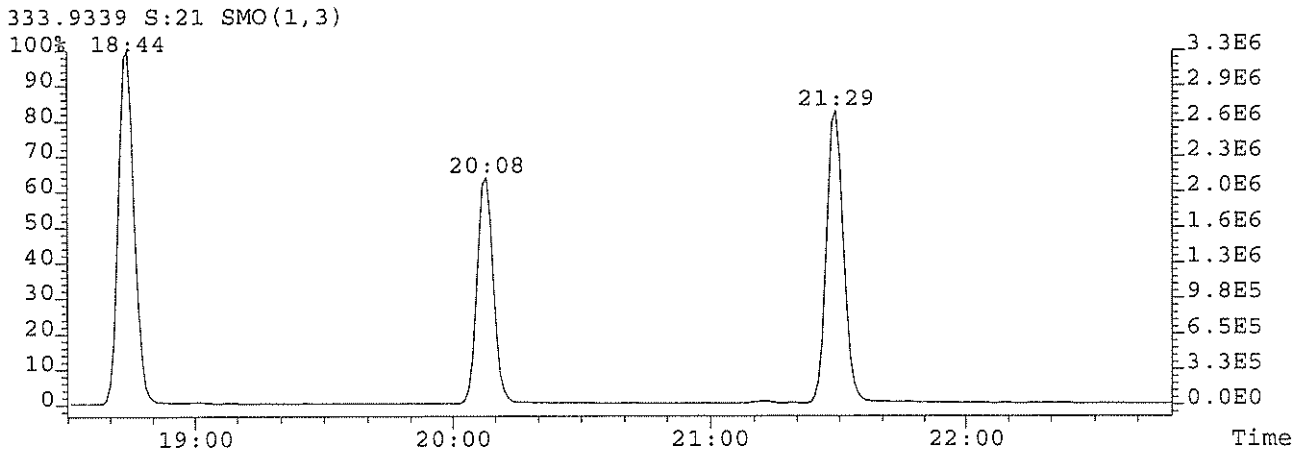
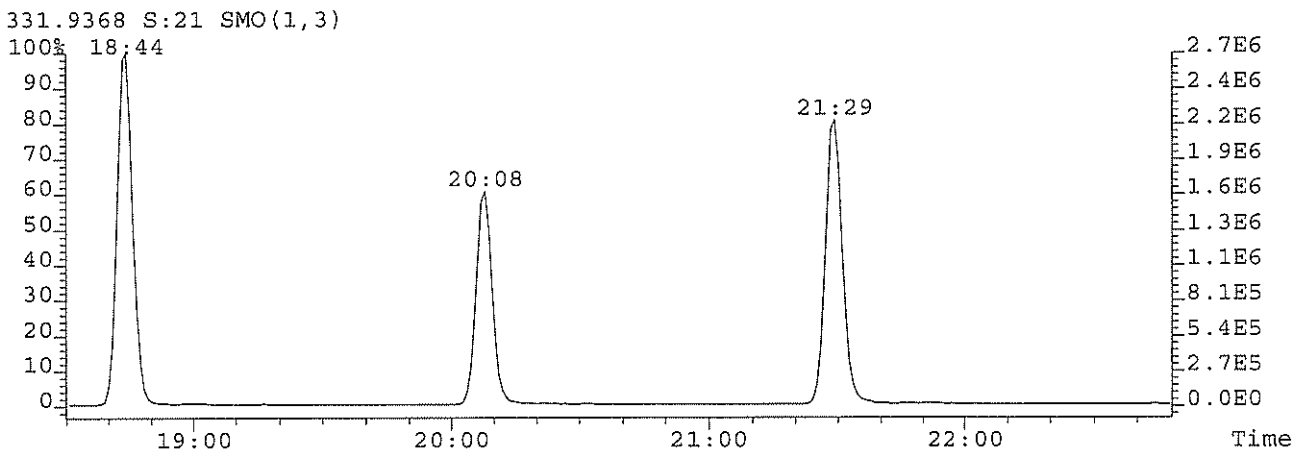
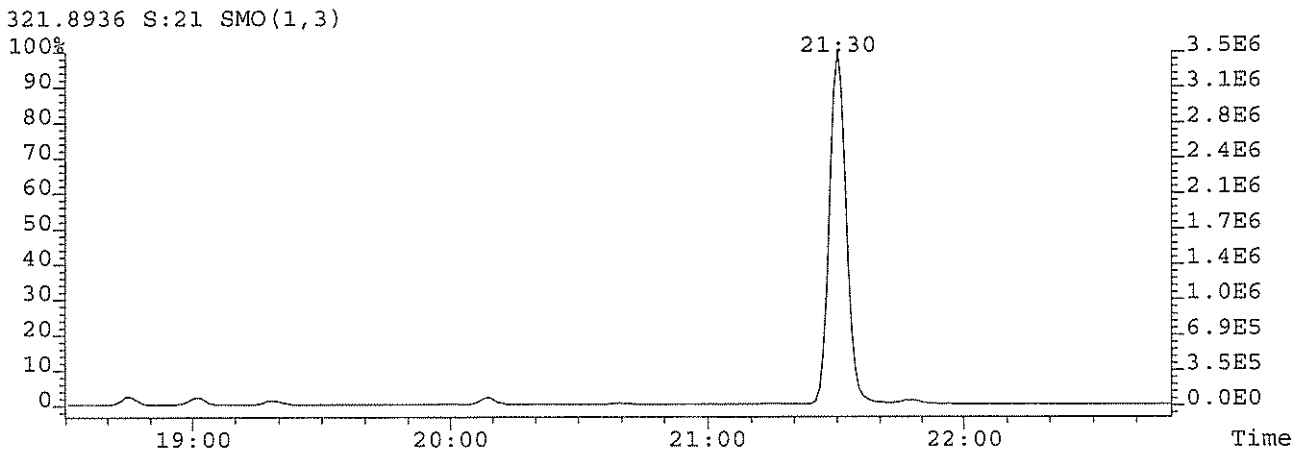
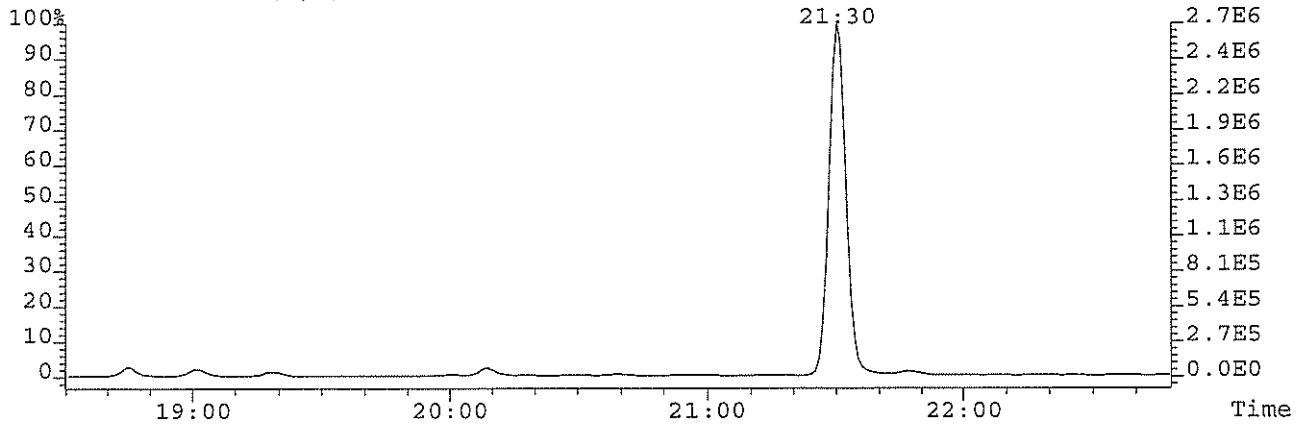


317.9389 S:21 SMO(1,3)



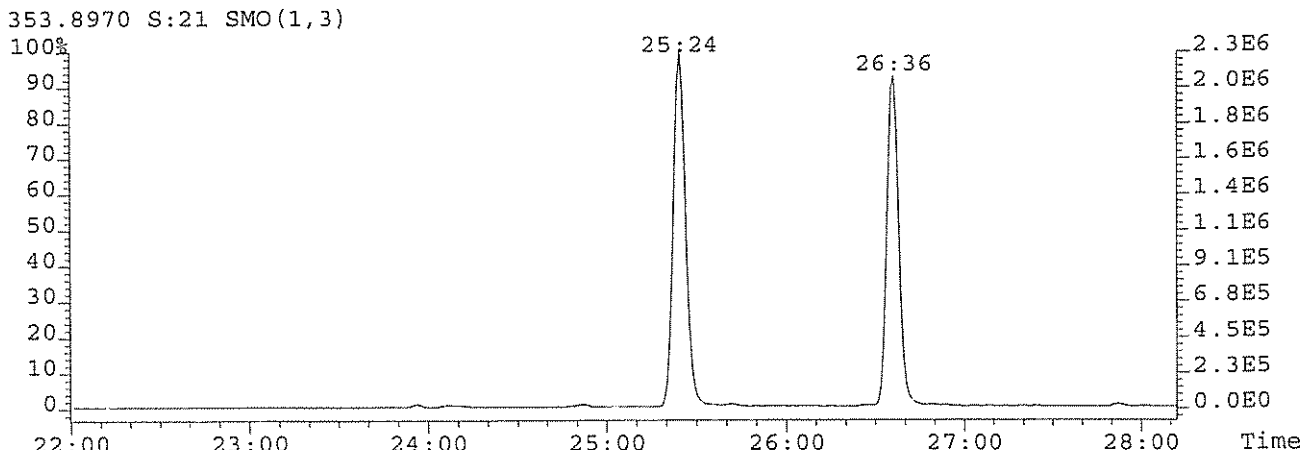
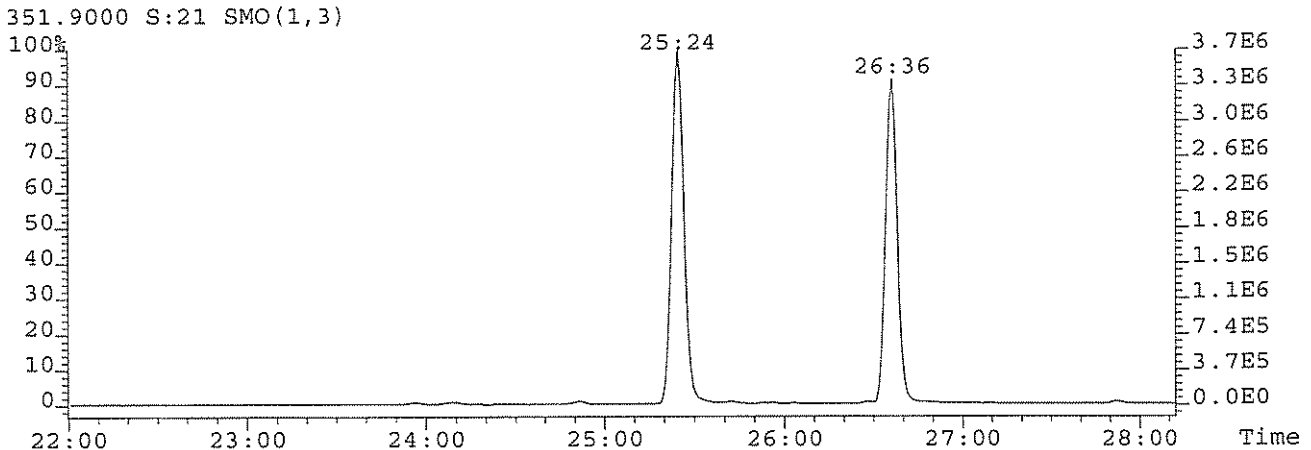
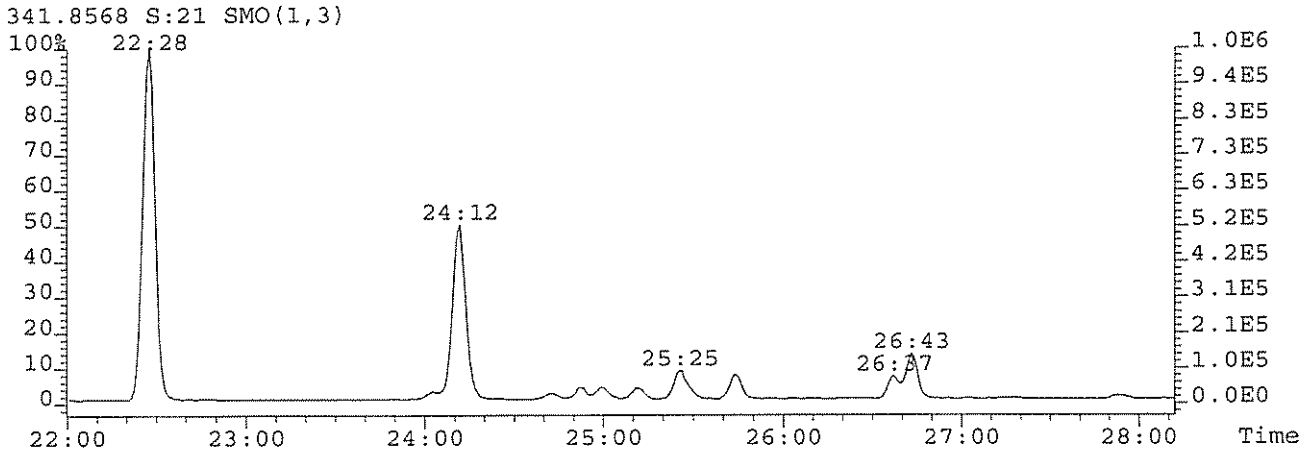
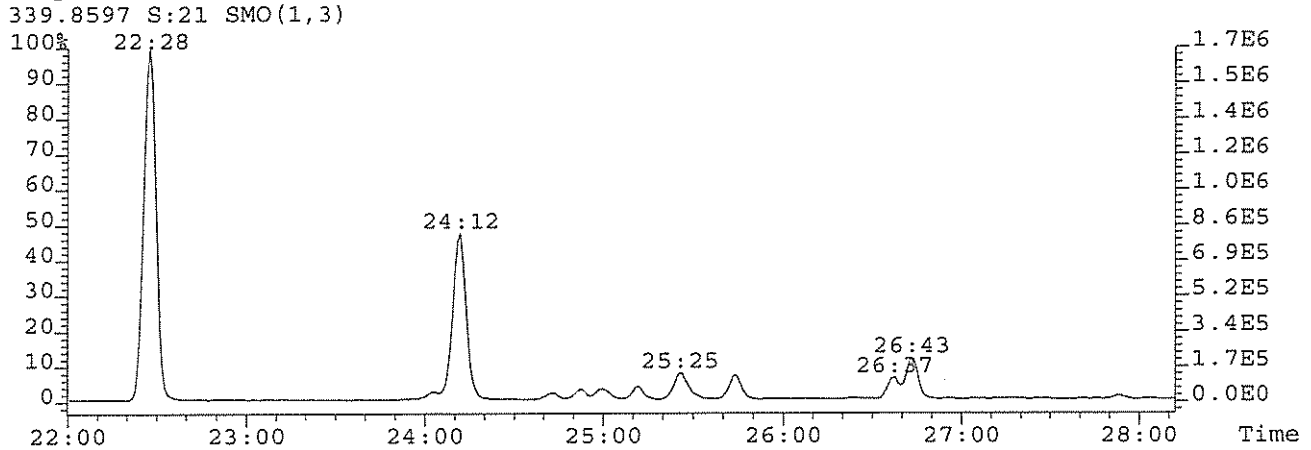
PCDFsクロマトグラム (1)  
(TeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 08:02:25 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:BPX-DXN(4-6DXN) Text:XE13 0964 Exp:BPX04  
319.8965 S:21 SMO(1,3)



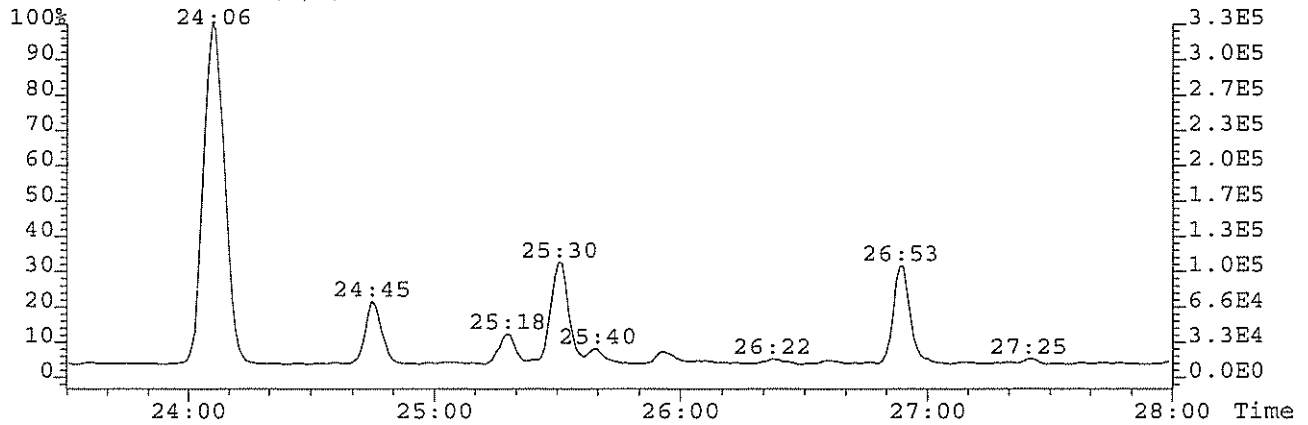
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130712-2 #1-1578 Acq:13-JUL-2013 08:02:25 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:BPX-DXN(4-6DXN) Text:XE13 0964 Exp:BPX04

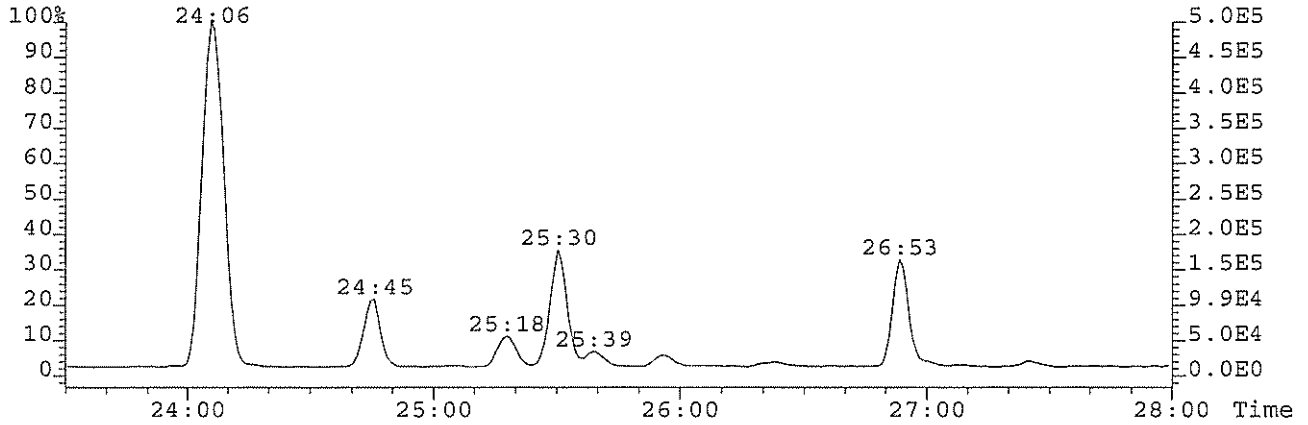


PCDFsクロマトグラム (3)  
(PeCDFs)

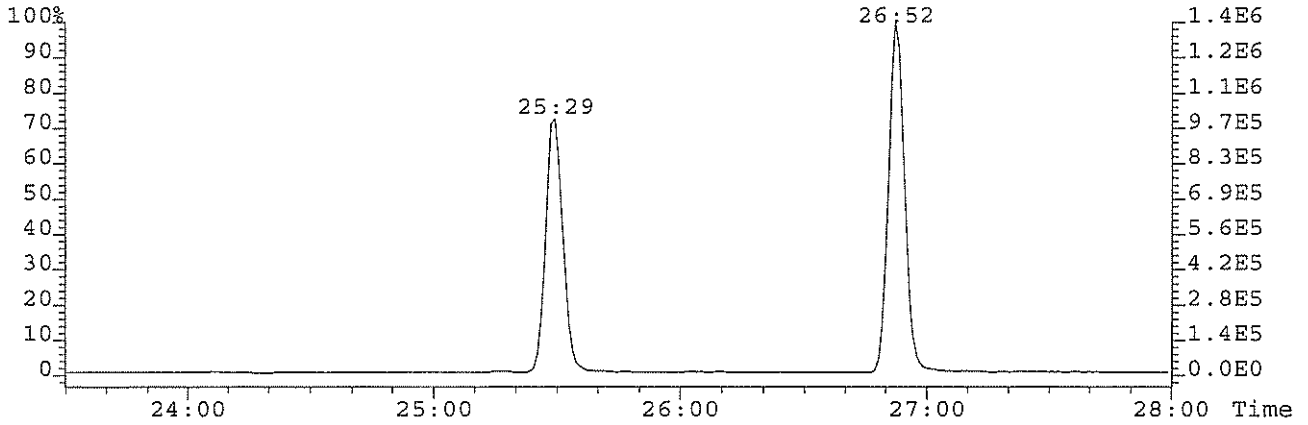
File:130712-2 #1-1578 Acq:13-JUL-2013 08:02:25 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:BPX-DXN(4-6DXN) Text:XE13 0964 Exp:BPX04  
353.8576 S:21 SMO(1,3)



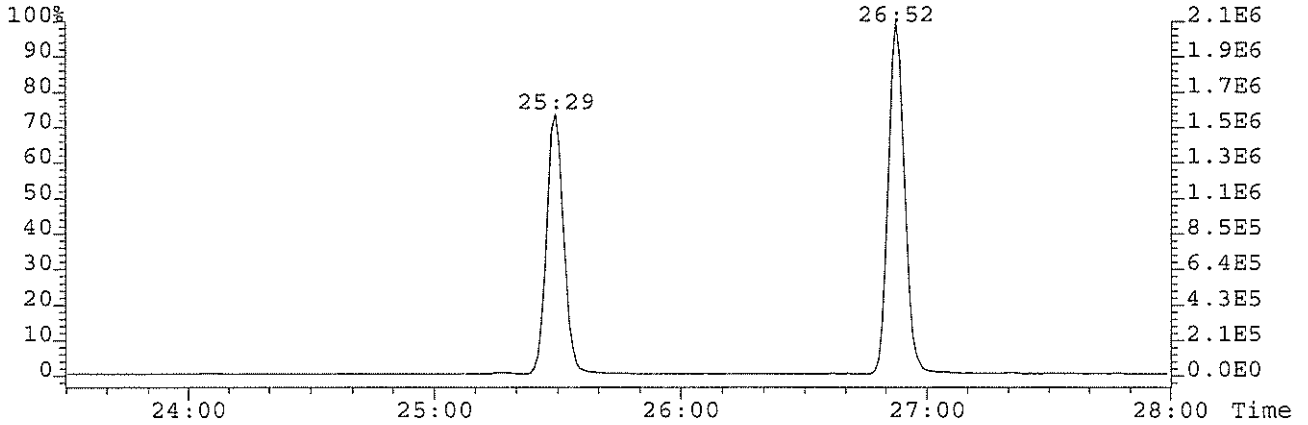
355.8546 S:21 SMO(1,3)



365.8978 S:21 SMO(1,3)

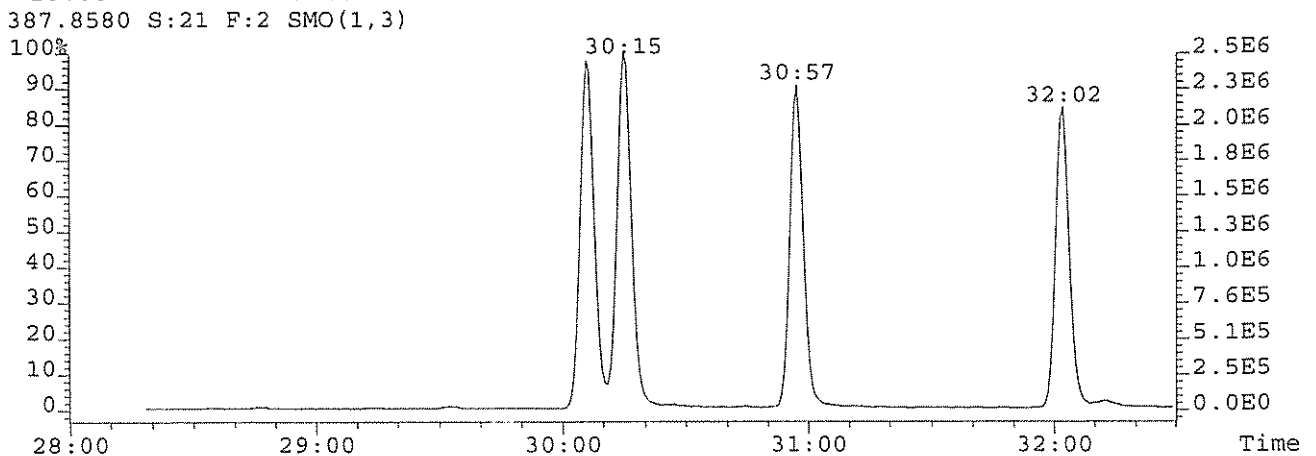
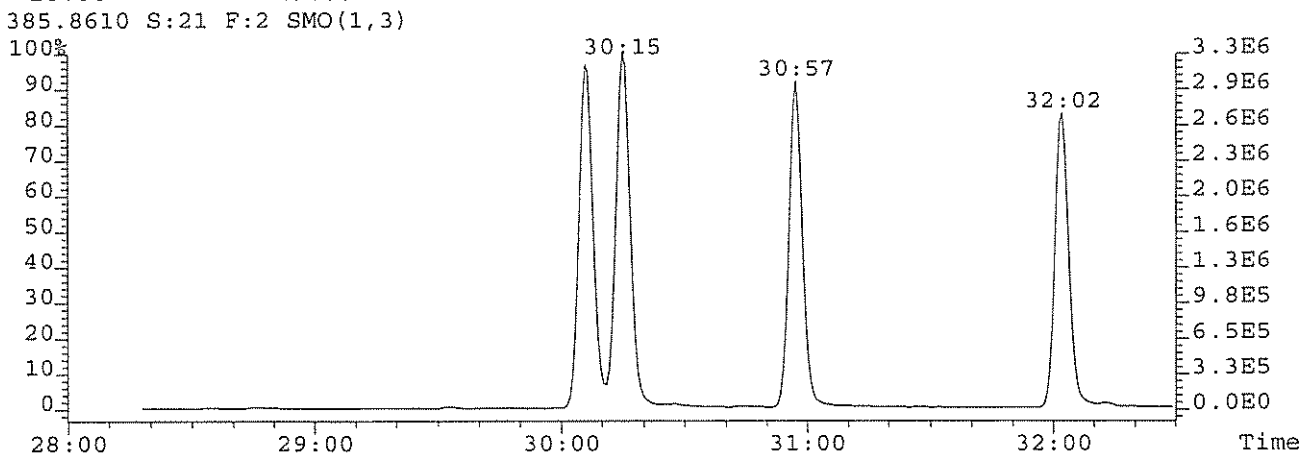
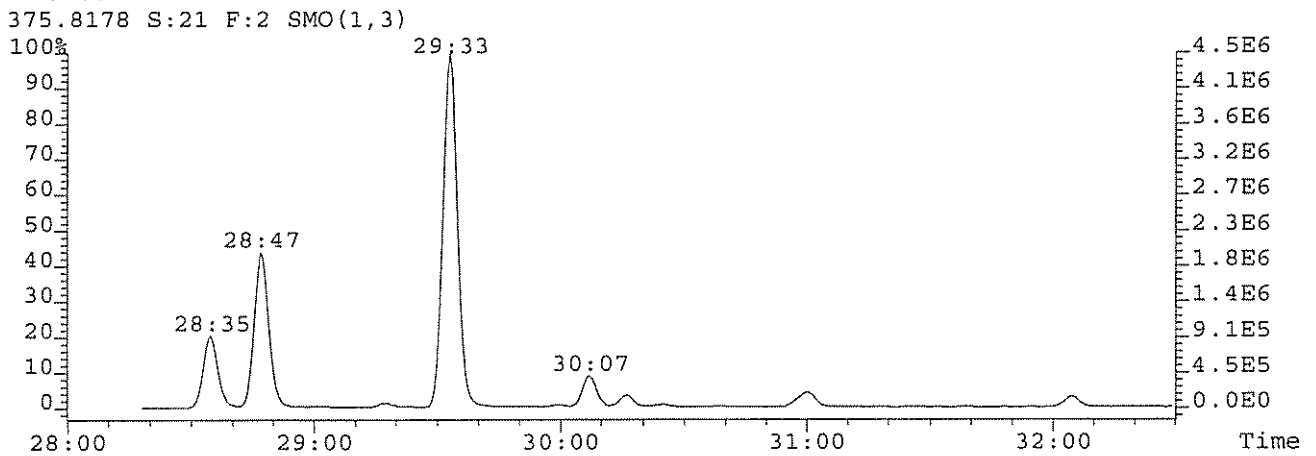
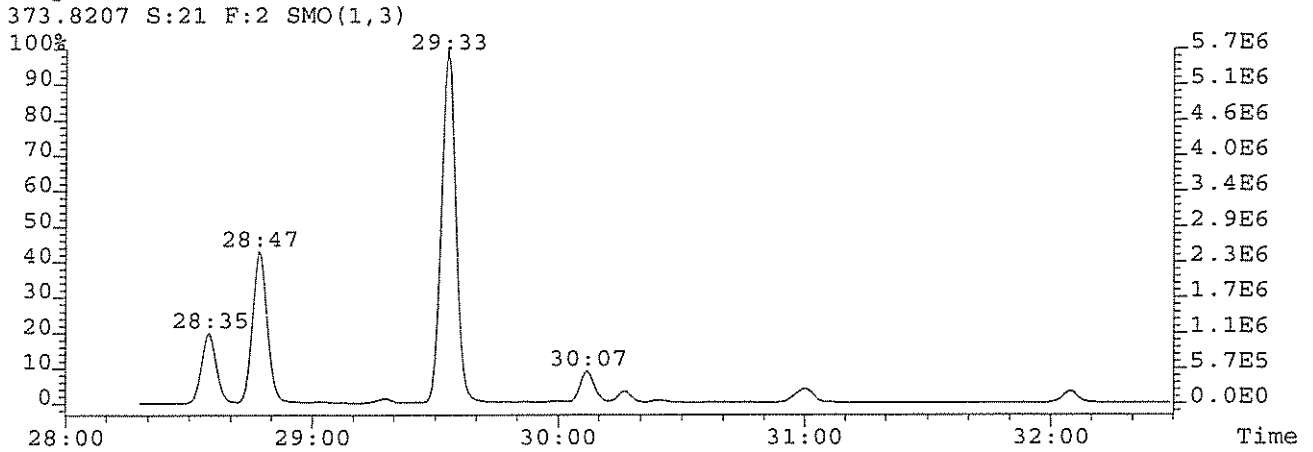


367.8949 S:21 SMO(1,3)



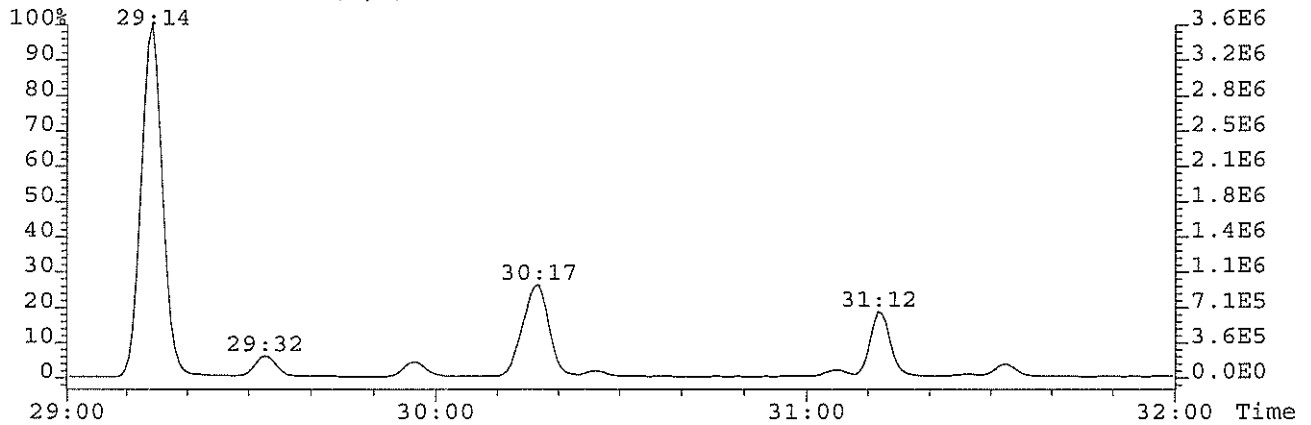
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130712-2 #1-1117 Acq:13-JUL-2013 08:02:25 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:BPX-DXN(4-6DXN) Text:XE13 0964 Exp:BPX04

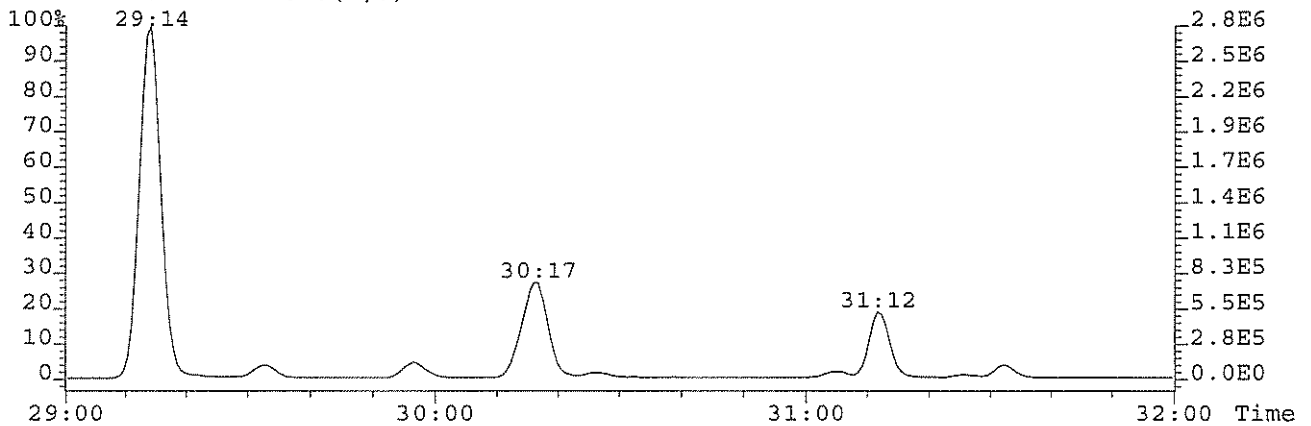


PCDFsクロマトグラム (5)  
(HxCDFs)

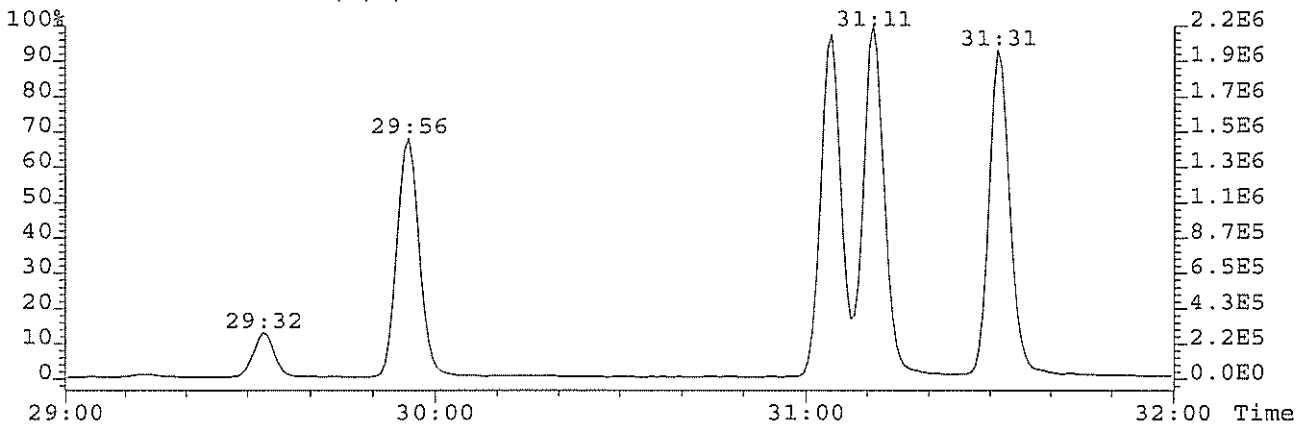
File:130712-2 #1-1117 Acq:13-JUL-2013 08:02:25 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:BPX-DXN(4-6DXN) Text:XE13 0964 Exp:BPX04  
389.8156 S:21 F:2 SMO(1,3)



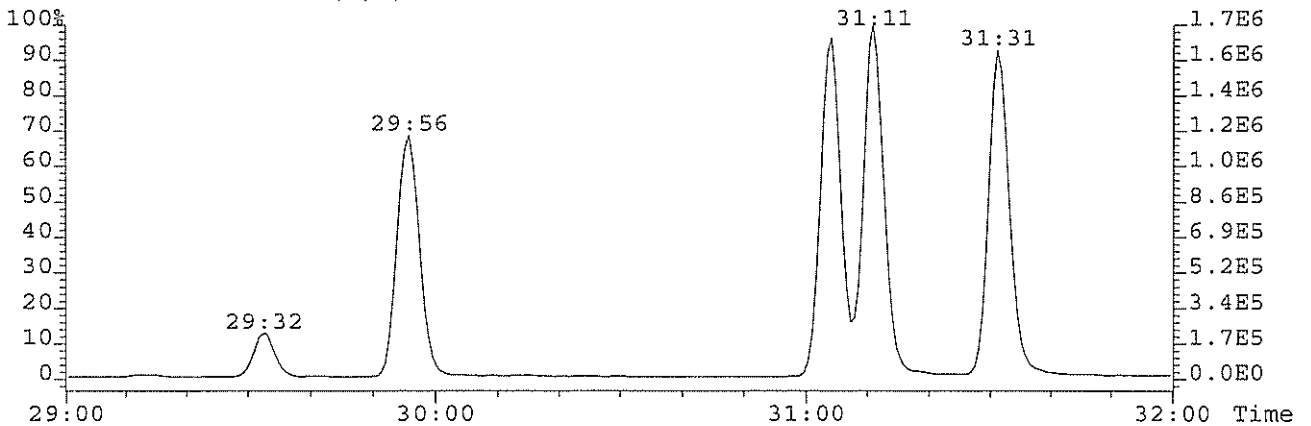
391.8127 S:21 F:2 SMO(1,3)



401.8559 S:21 F:2 SMO(1,3)



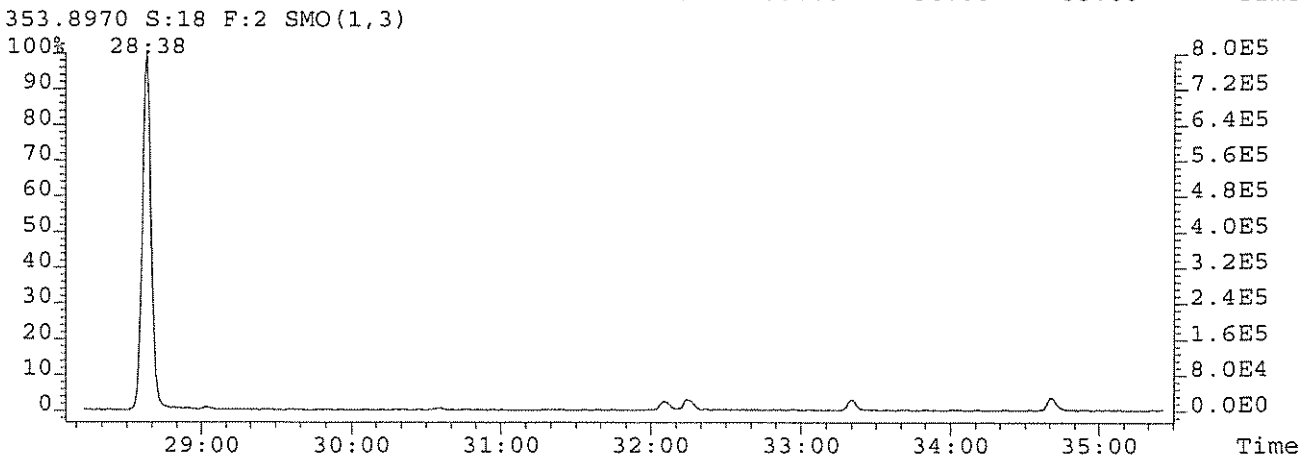
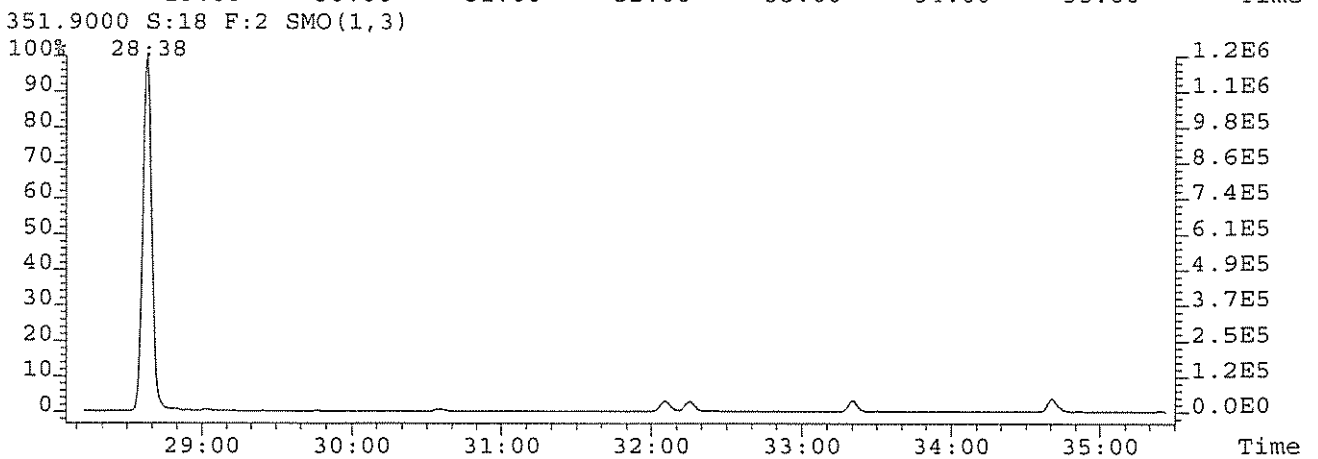
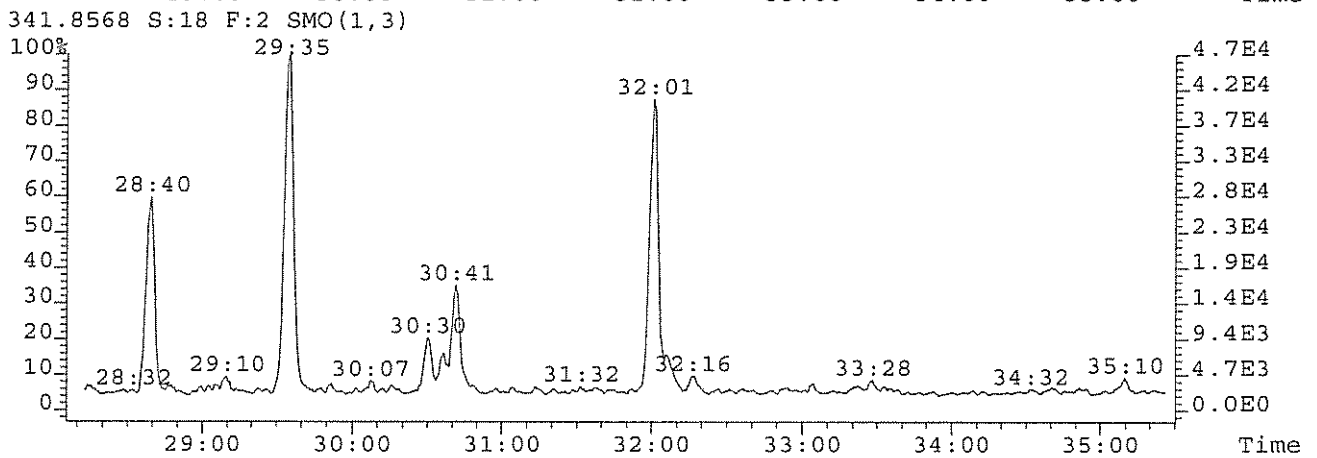
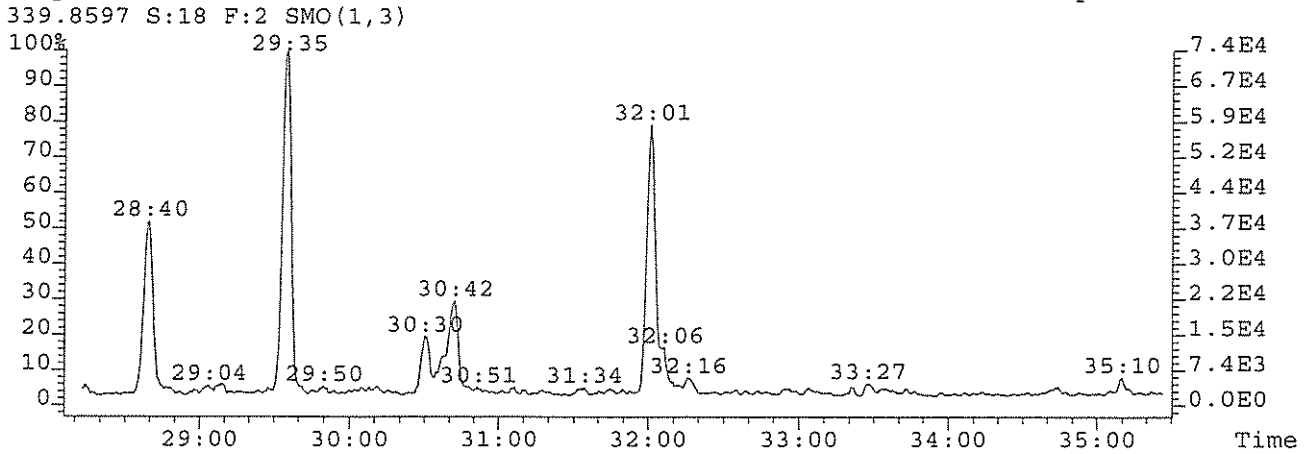
403.8530 S:21 F:2 SMO(1,3)



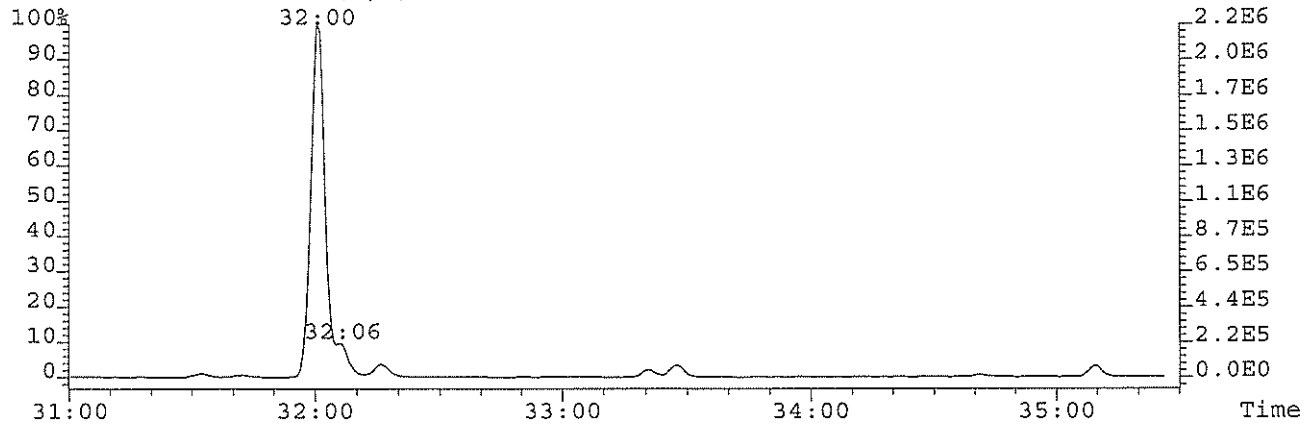
PCDDsクロマトグラム (6)  
(HxCDDs)



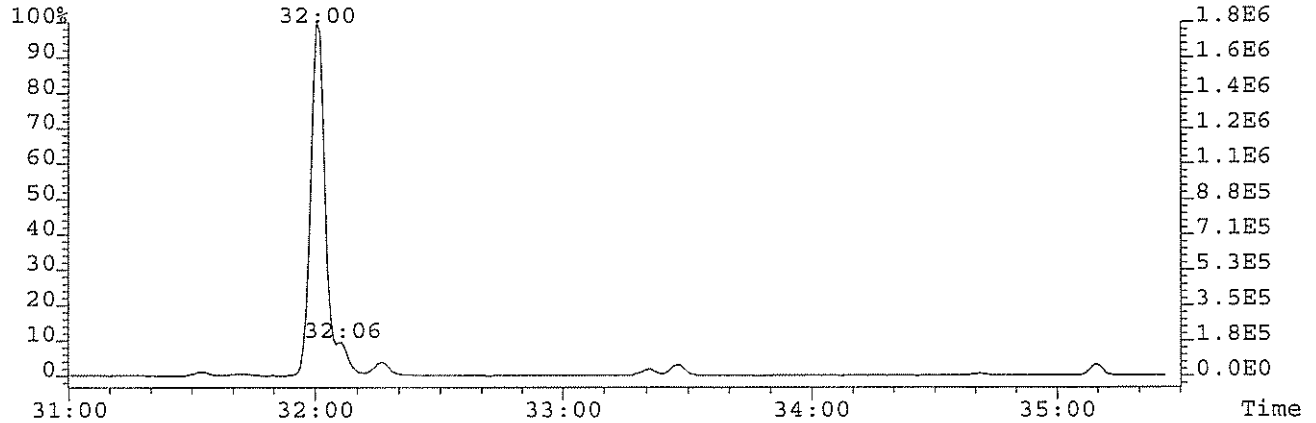
File:130713 #1-649 Acq:14-JUL-2013 02:16:24 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0964 3 Exp:RH-PD22



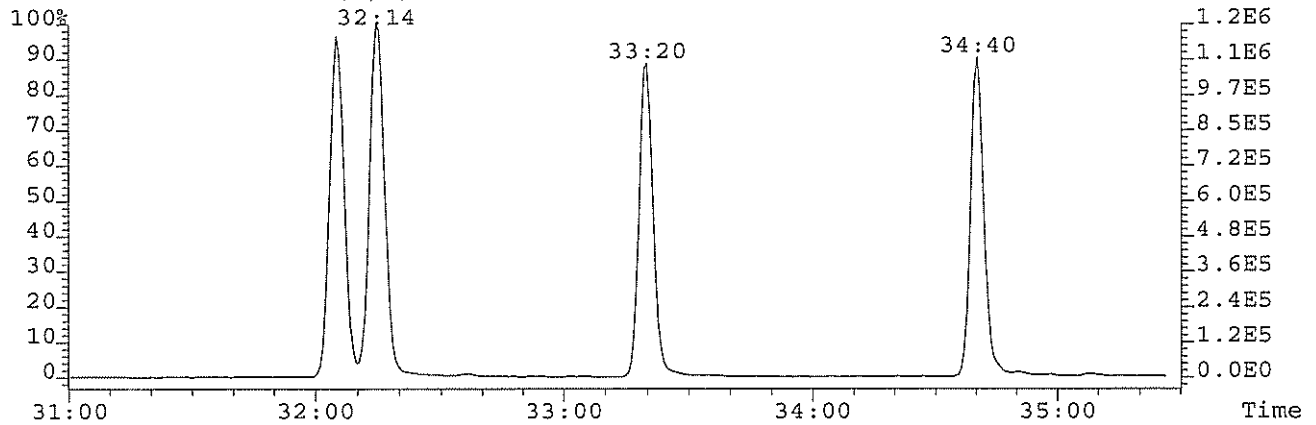
File:130713 #1-649 Acq:14-JUL-2013 02:16:24 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0964 3 Exp:RH-PD22  
373.8207 S:18 F:2 SMO(1,3)



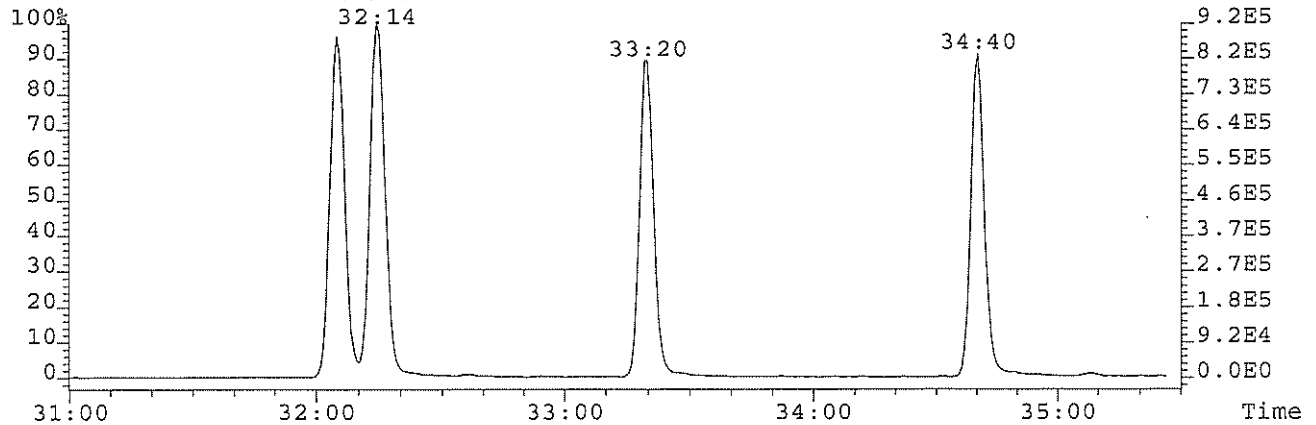
375.8178 S:18 F:2 SMO(1,3)



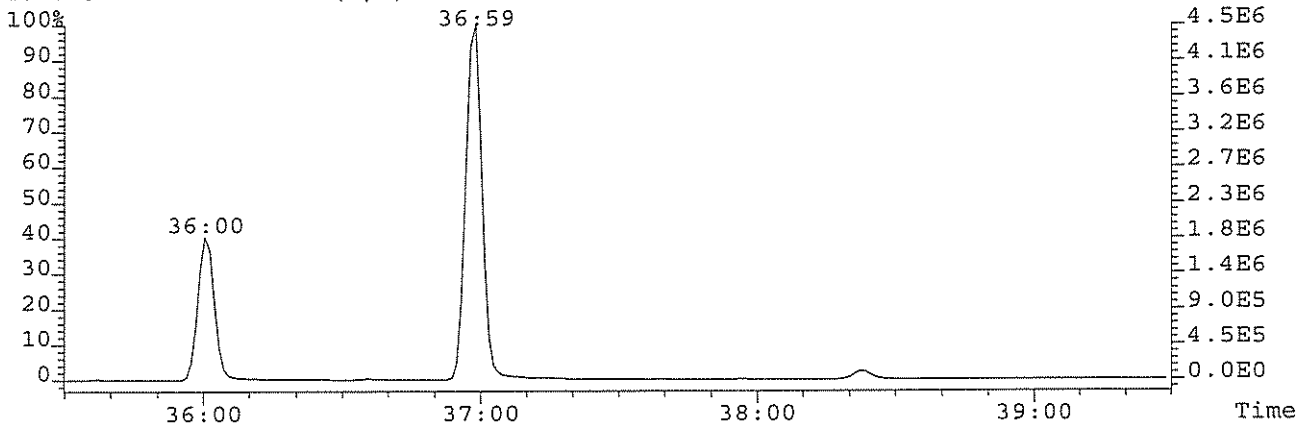
385.8610 S:18 F:2 SMO(1,3)



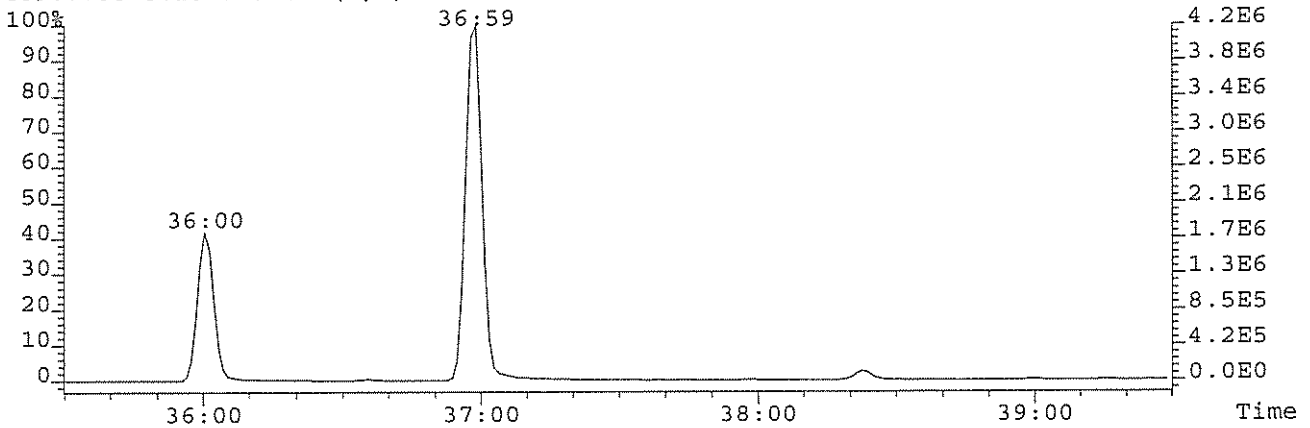
387.8580 S:18 F:2 SMO(1,3)



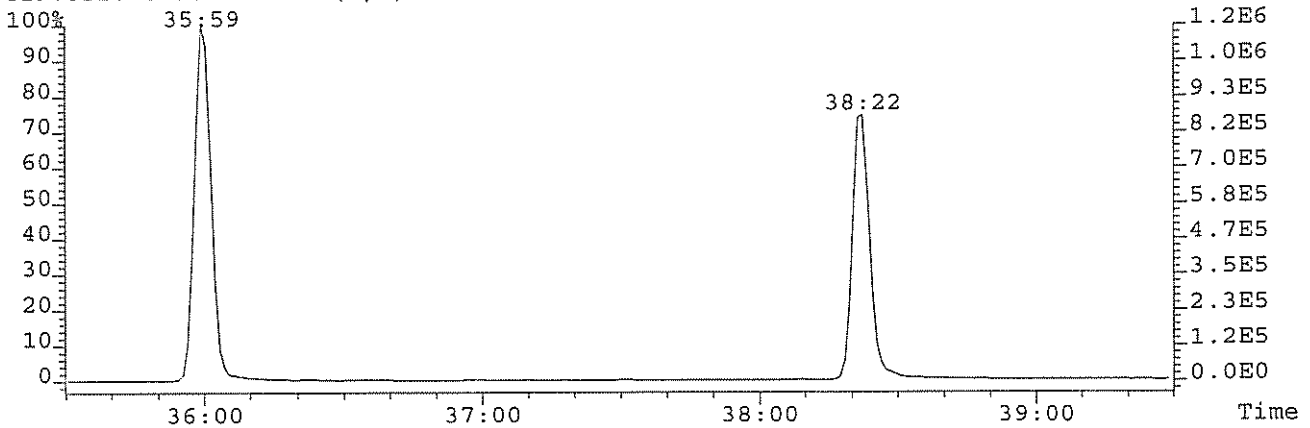
File:130713 #1-563 Acq:14-JUL-2013 02:16:24 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0964 3 Exp:RH-PD22  
407.7818 S:18 F:3 SMO(1,3)



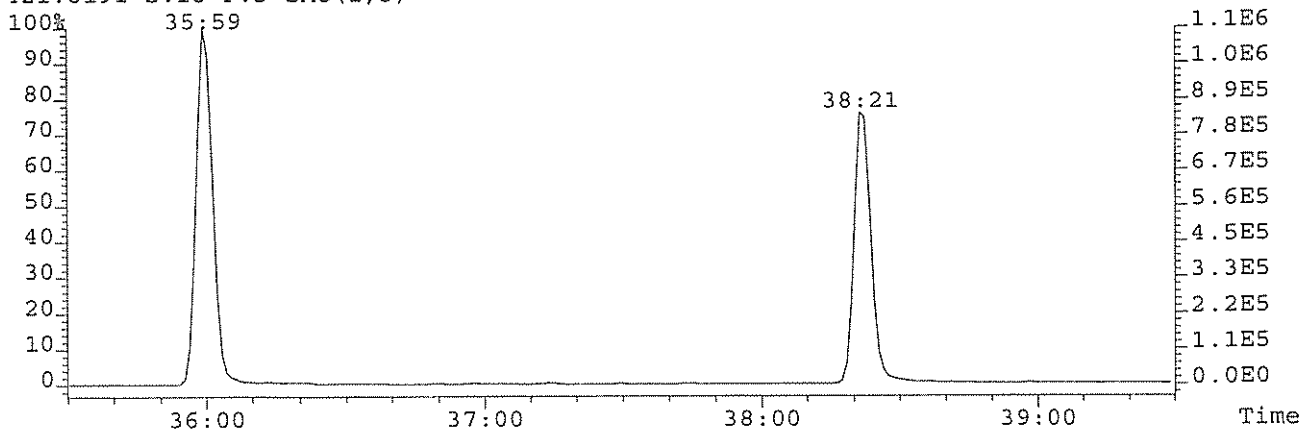
409.7788 S:18 F:3 SMO(1,3)



419.8220 S:18 F:3 SMO(1,3)

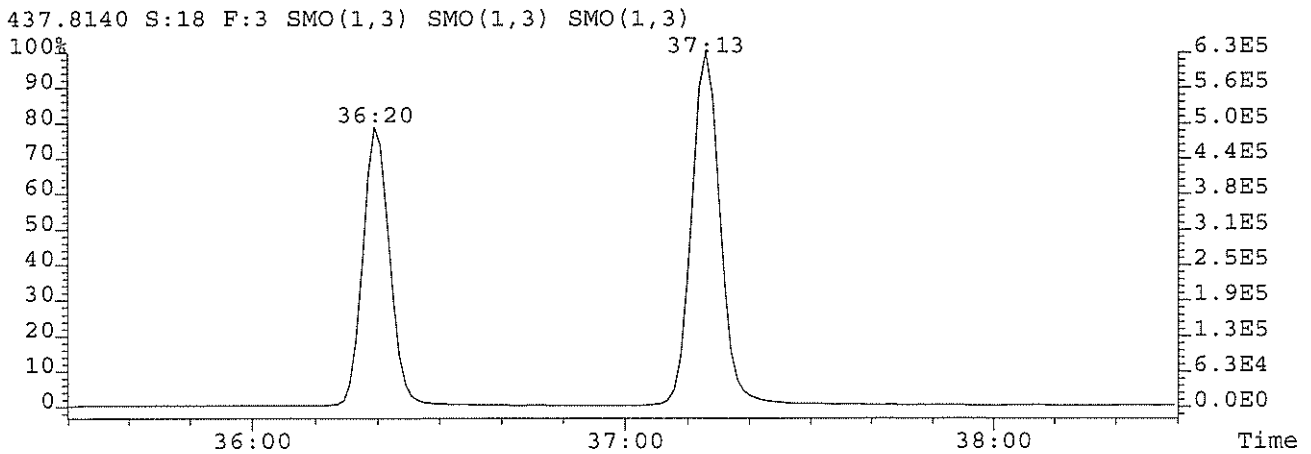
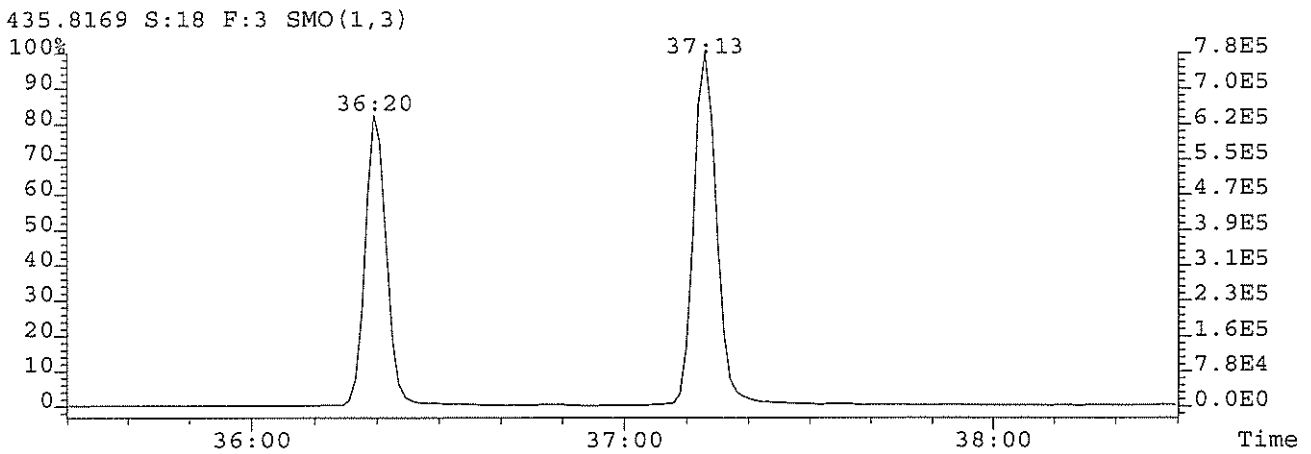
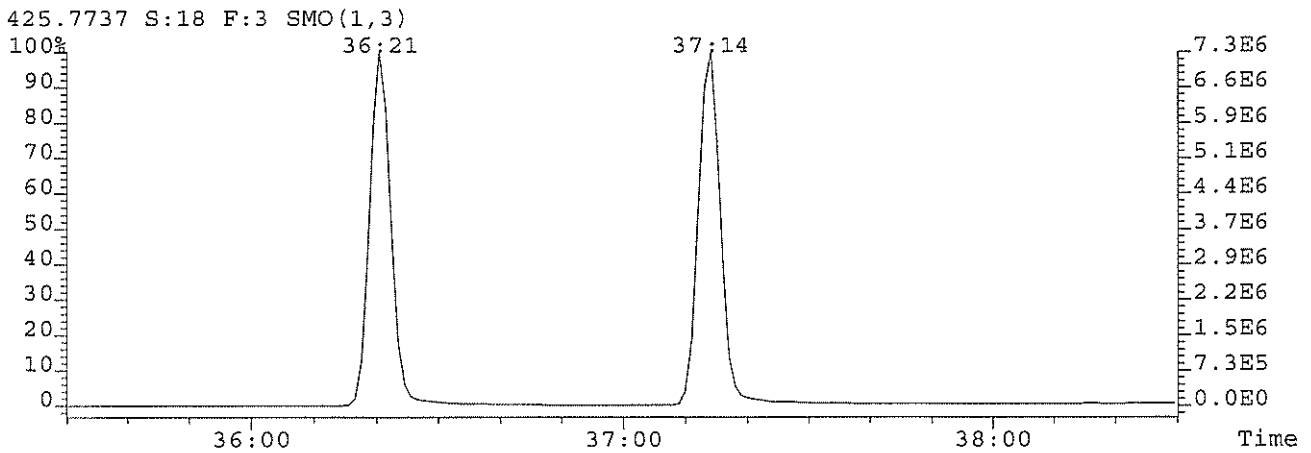
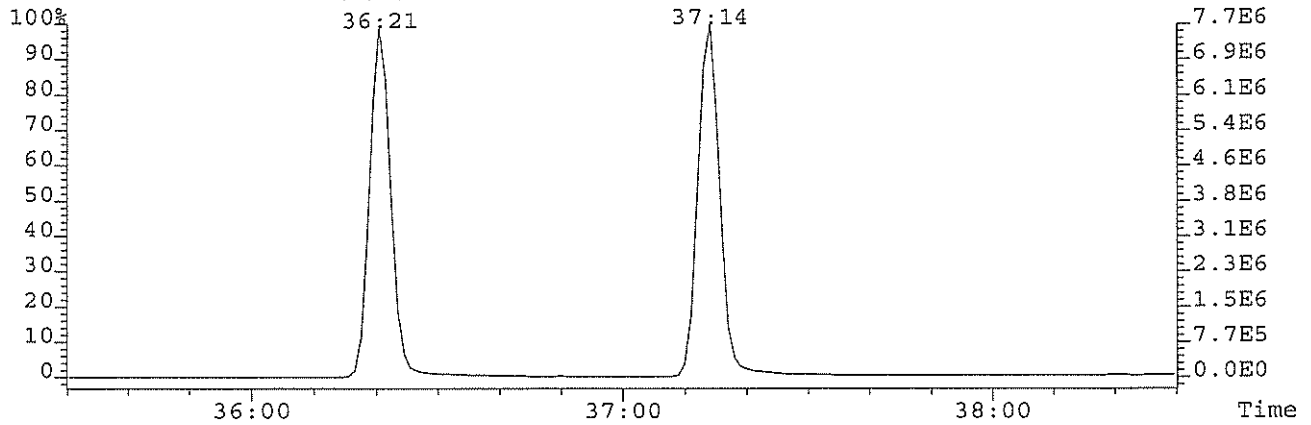


421.8191 S:18 F:3 SMO(1,3)



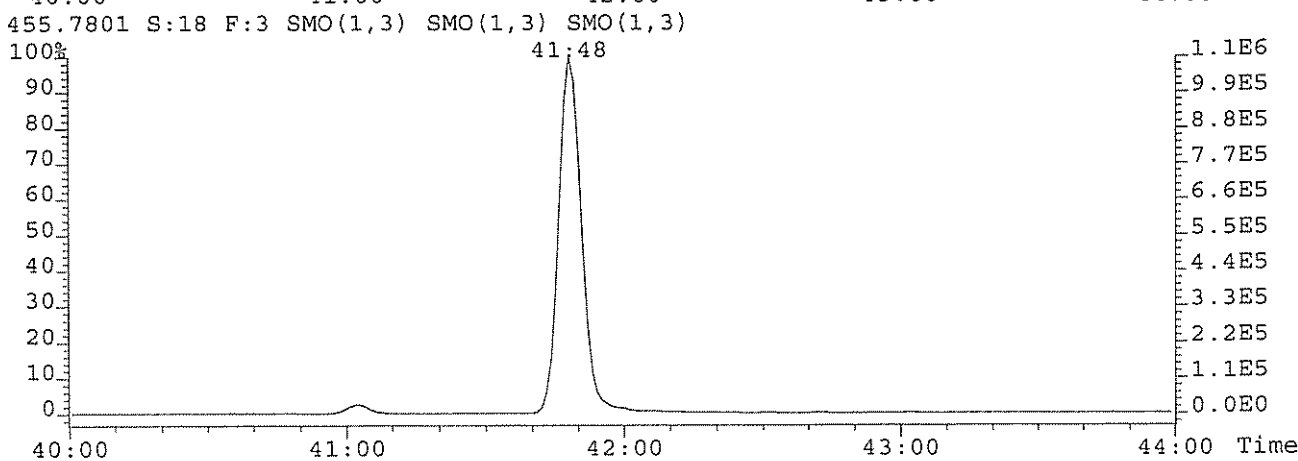
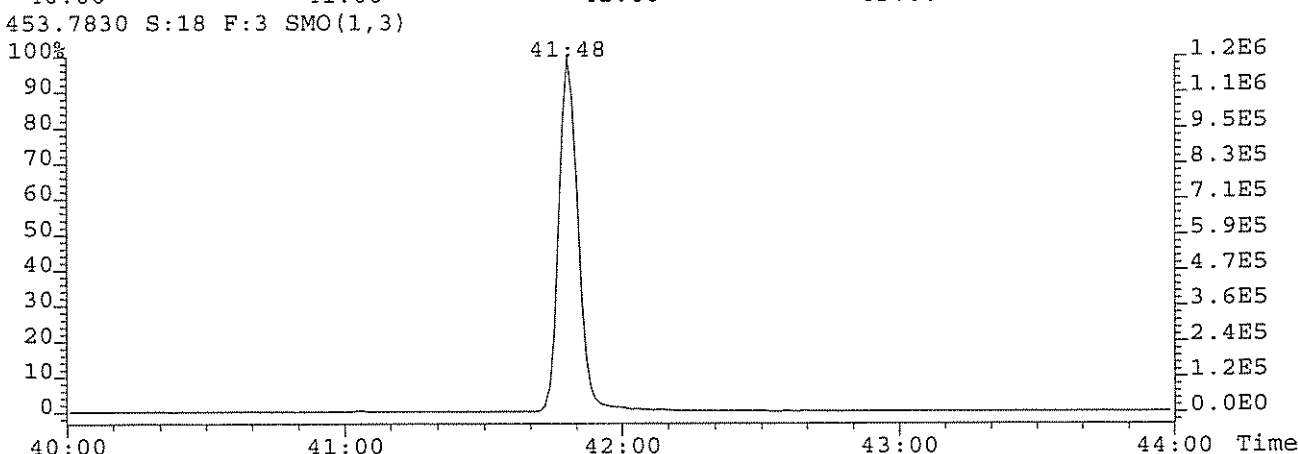
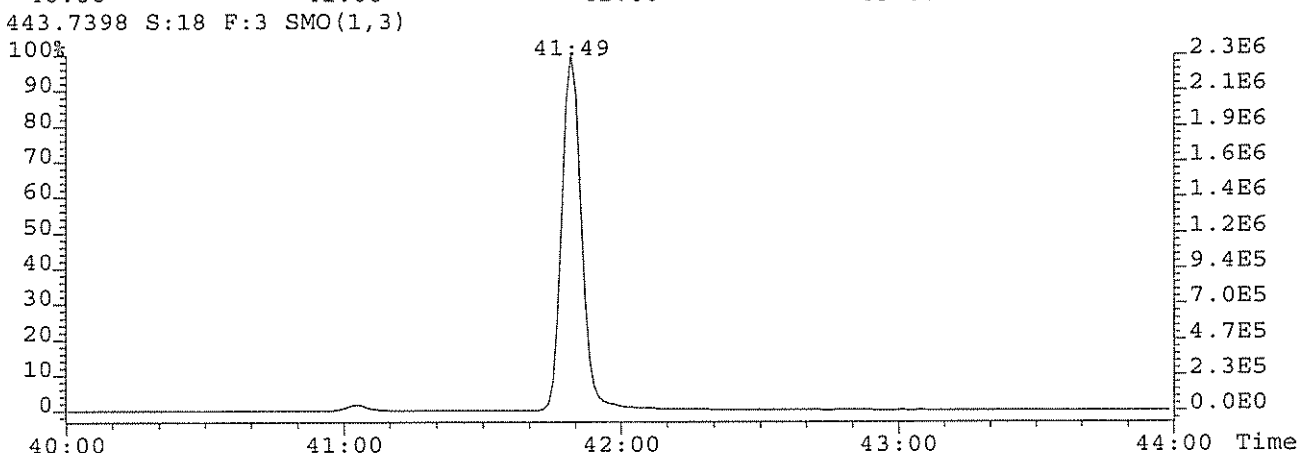
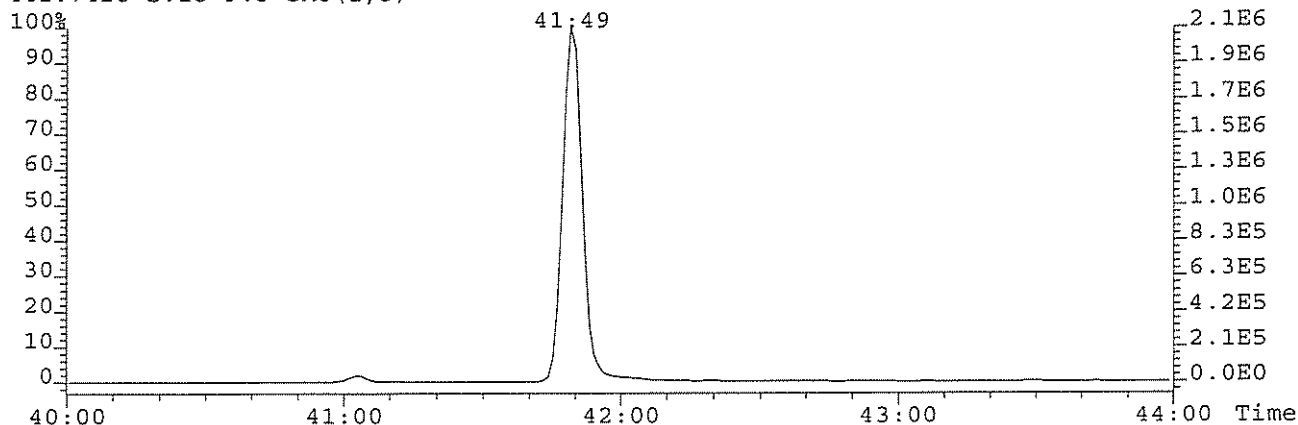
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130713 #1-563 Acq:14-JUL-2013 02:16:24 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0964 3 Exp:RH-PD22  
423.7767 S:18 F:3 SMO(1,3)



PCDDsクロマトグラム (10)  
(HpCDDs)

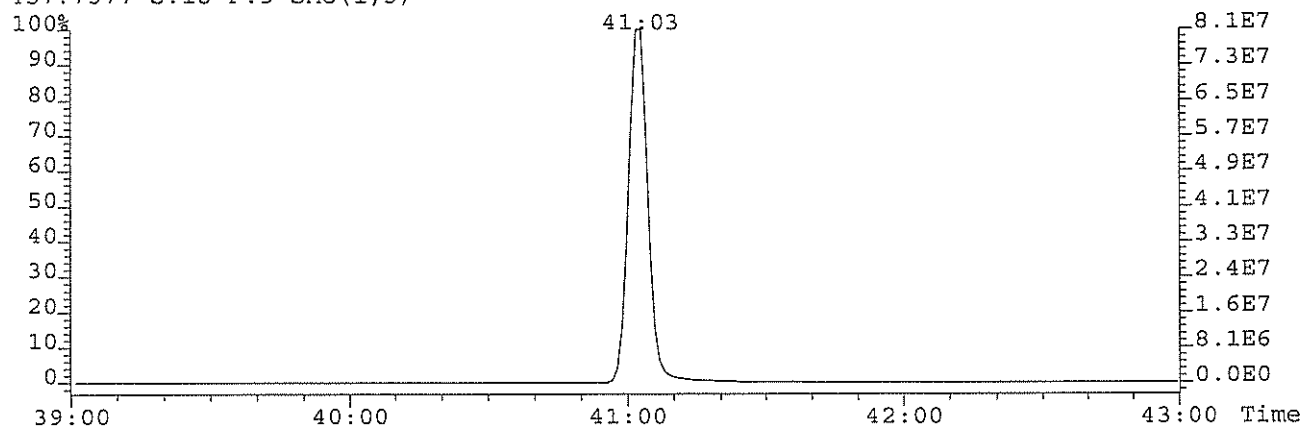
File:130713 #1-563 Acq:14-JUL-2013 02:16:24 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0964 3 Exp:RH-PD22  
441.7428 S:18 F:3 SMO(1,3)



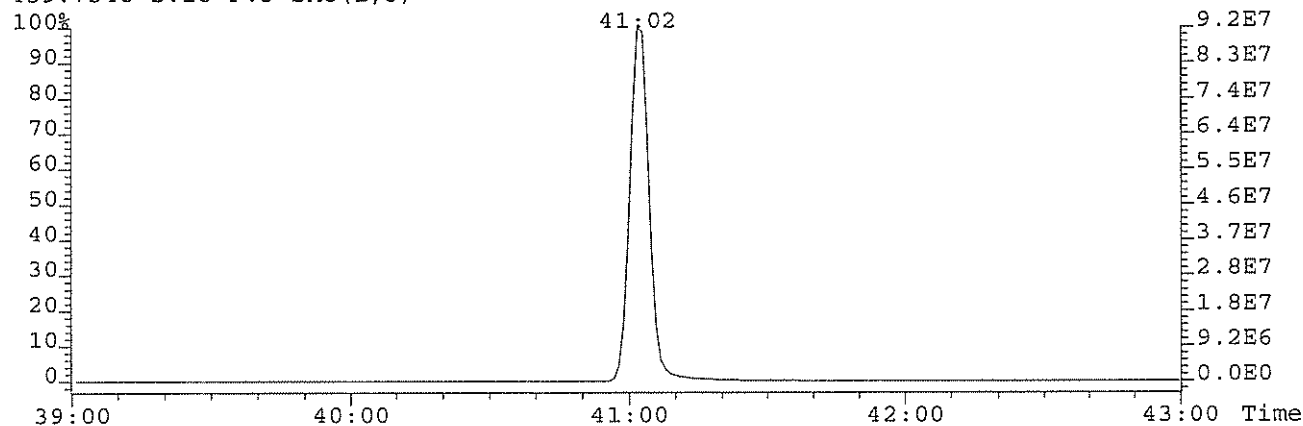
PCDFsクロマトグラム (11)  
(OCDF)

File:130713 #1-563 Acq:14-JUL-2013 02:16:24 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0964 3 Exp:RH-PD22

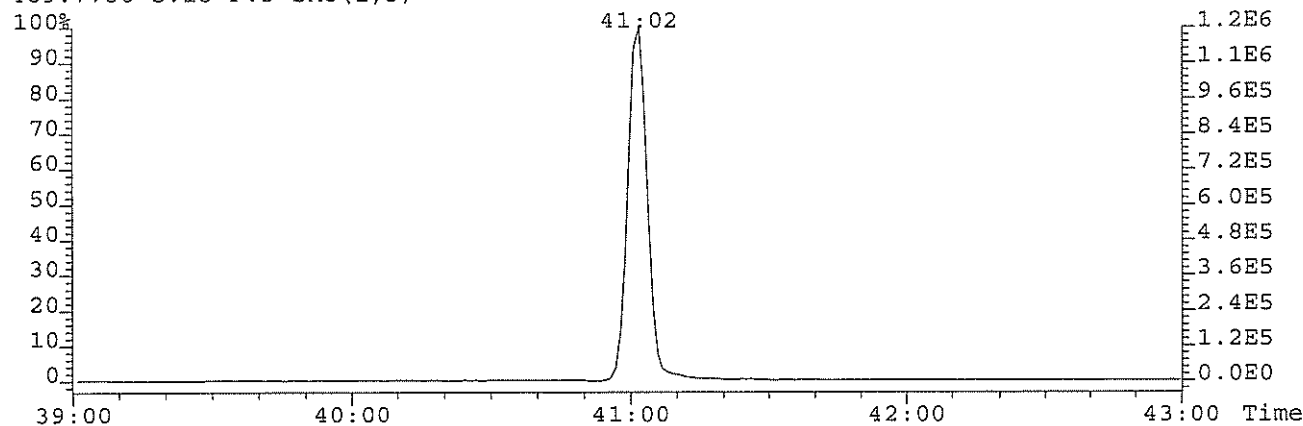
457.7377 S:18 F:3 SMO(1,3)



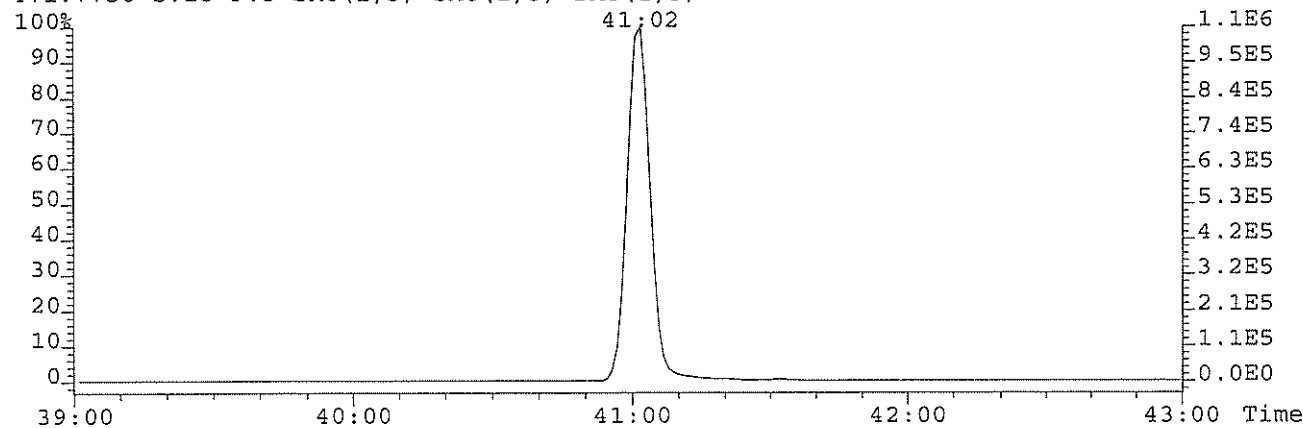
459.7348 S:18 F:3 SMO(1,3)



469.7780 S:18 F:3 SMO(1,3)

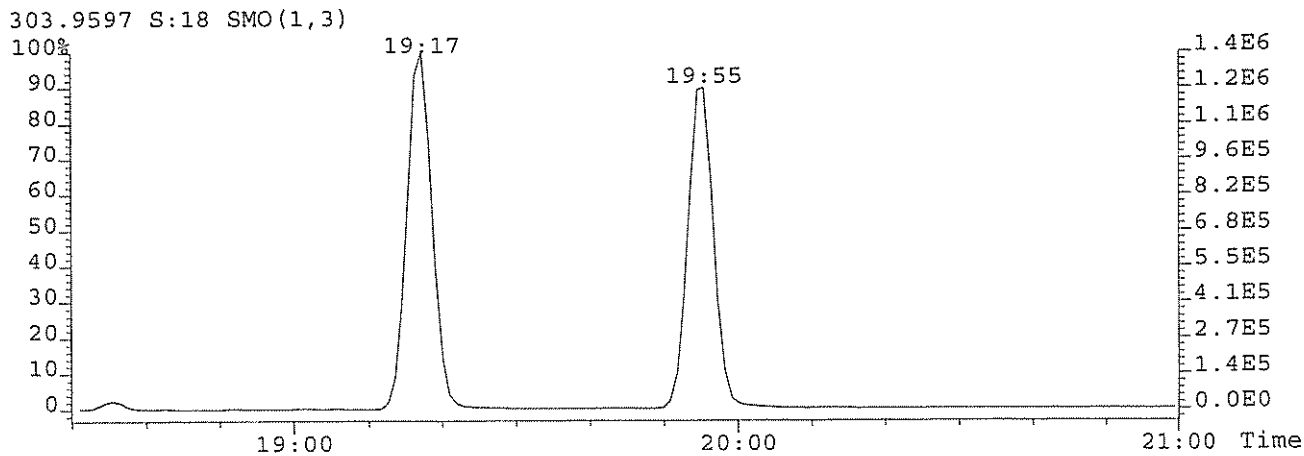
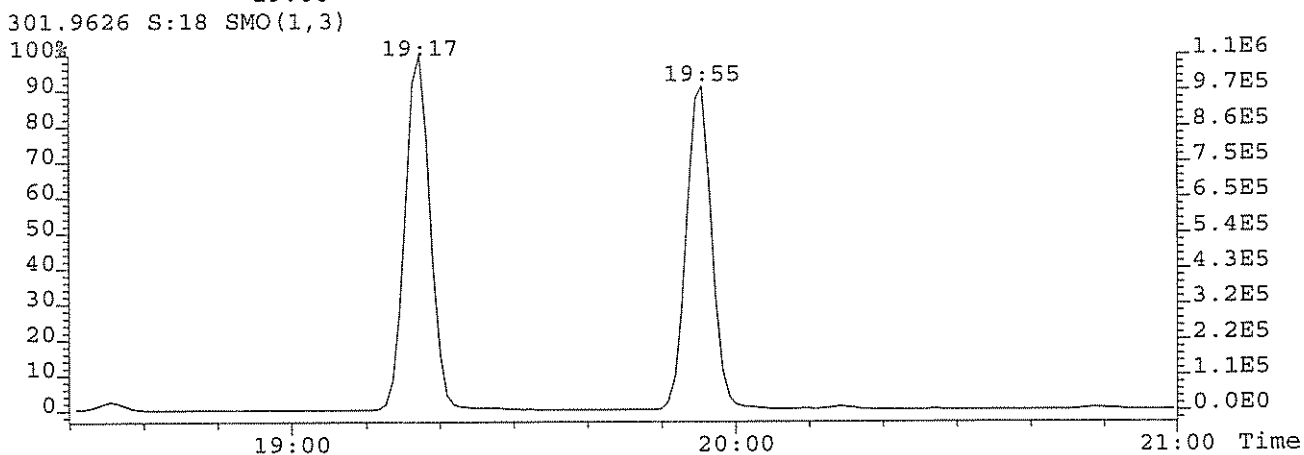
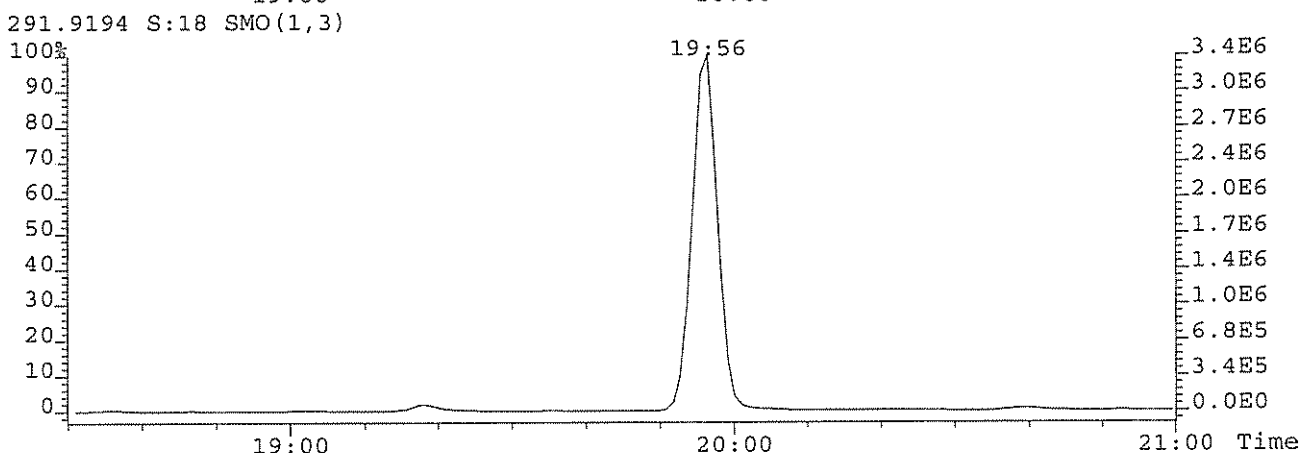
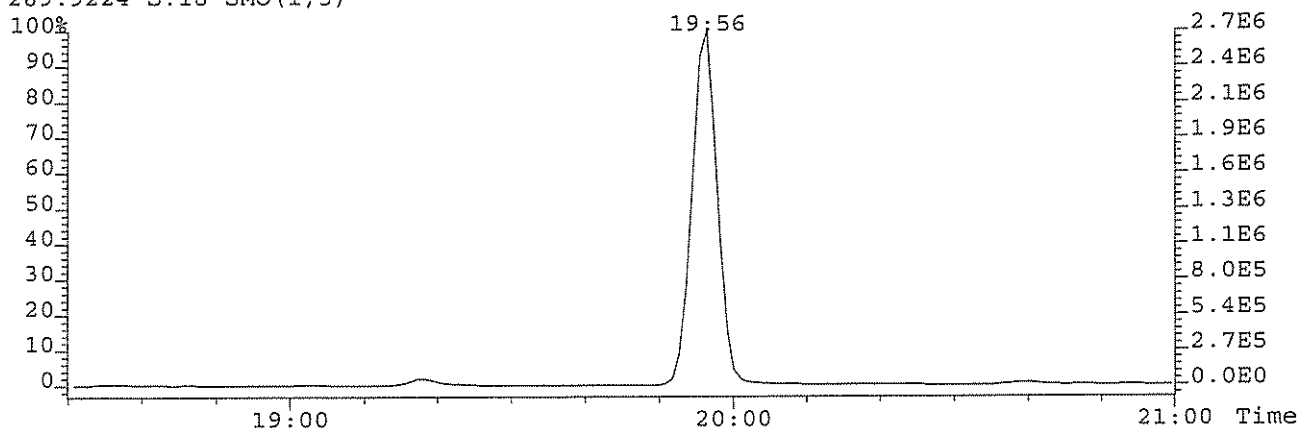


471.7750 S:18 F:3 SMO(1,3) SMO(1,3) SMO(1,3)



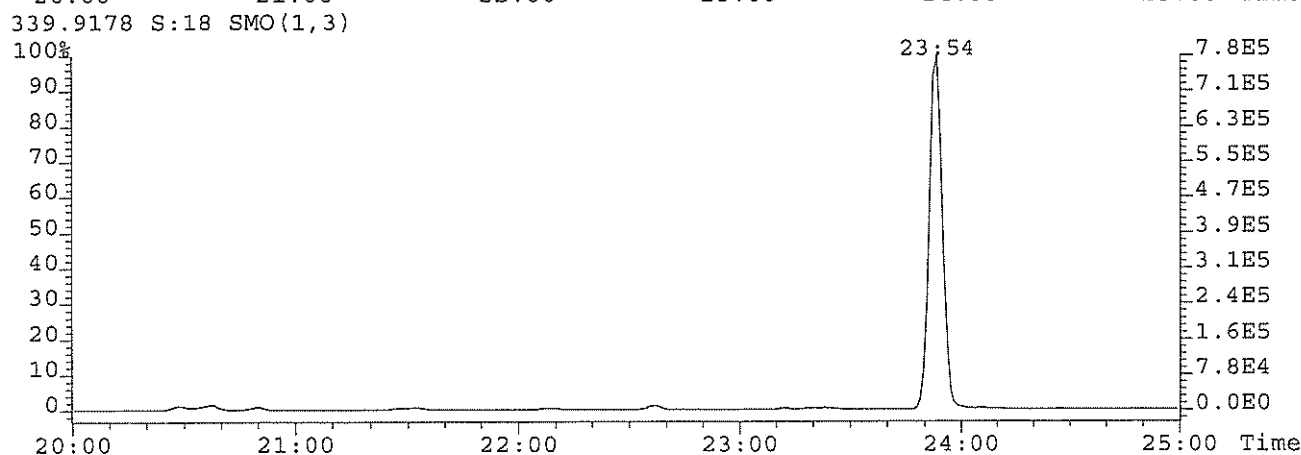
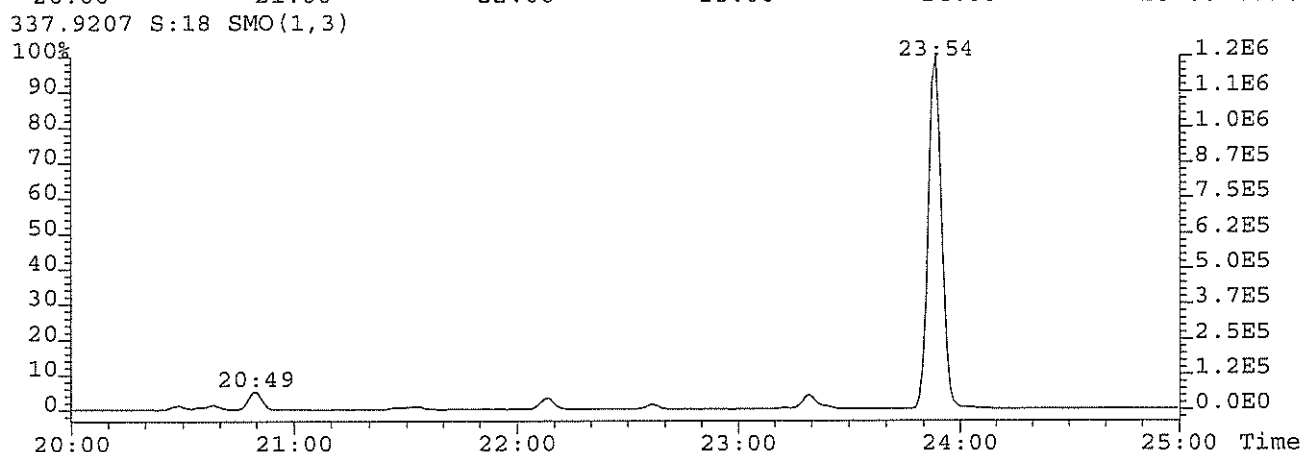
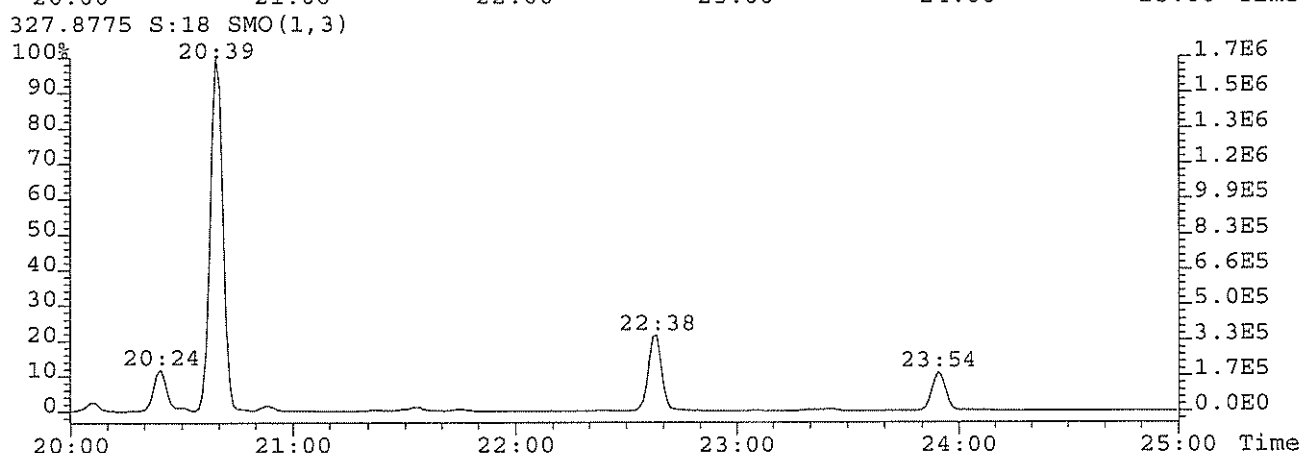
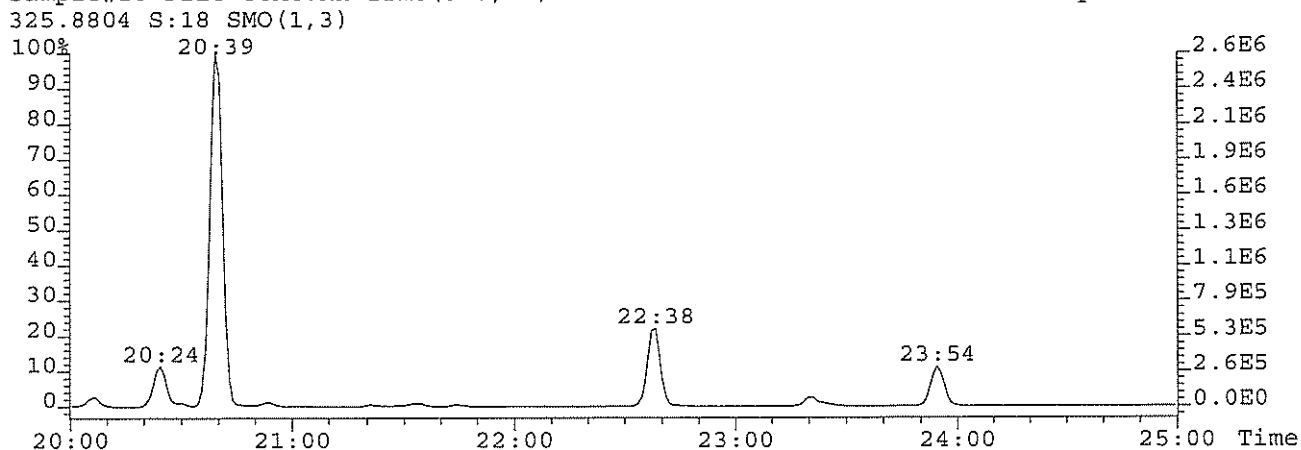
PCDDsクロマトグラム (12)  
(OCDD)

File:130713 #1-1430 Acq:14-JUL-2013 02:16:24 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0964 3 Exp:RH-PD22  
289.9224 S:18 SMO(1,3)



DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130713 #1-1430 Acq:14-JUL-2013 02:16:24 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0964 3 Exp:RH-PD22

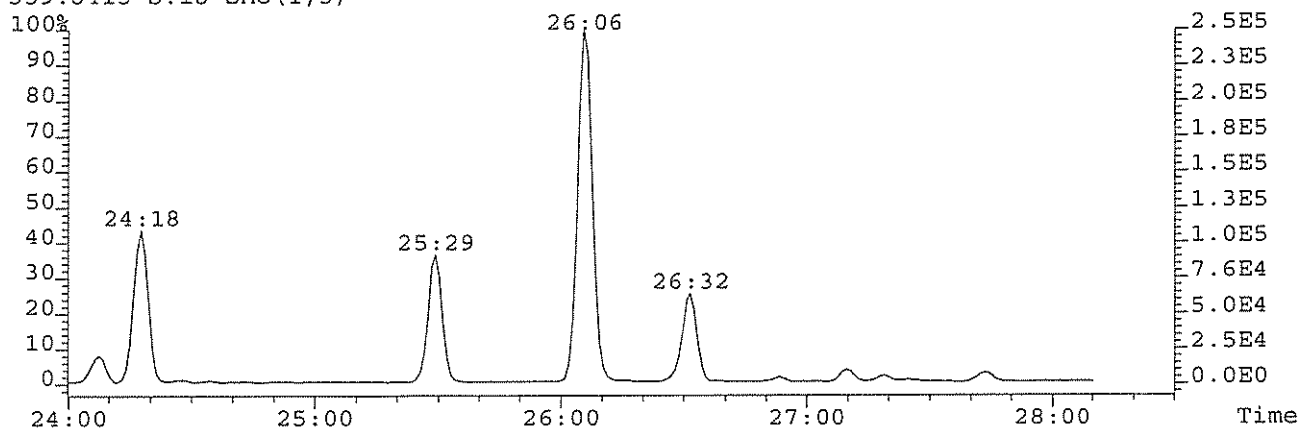


DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

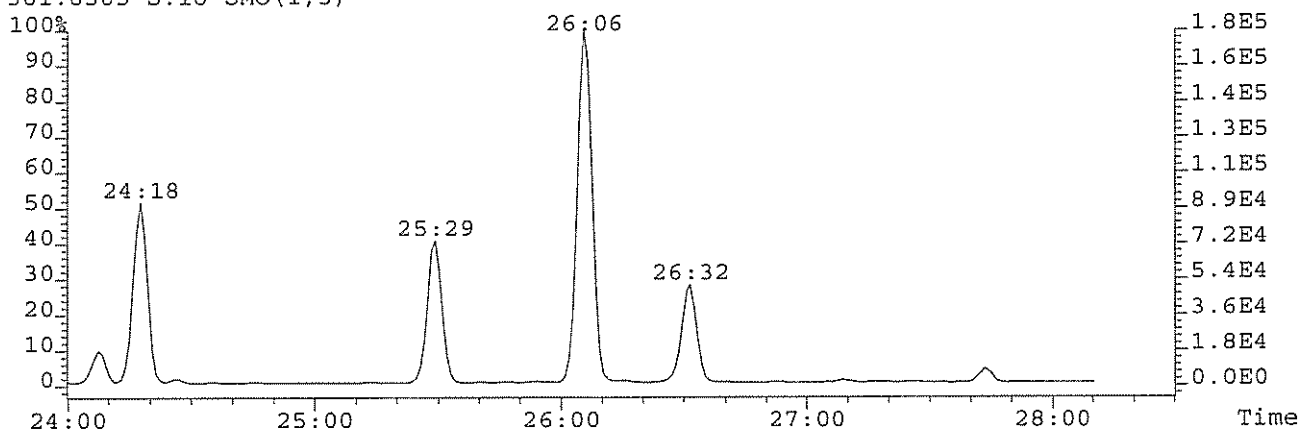


File:130713 #1-1430 Acq:14-JUL-2013 02:16:24 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#18 File Text:RH-12ms(5-8,nP) Text:XE13 0964 3 Exp:RH-PD22

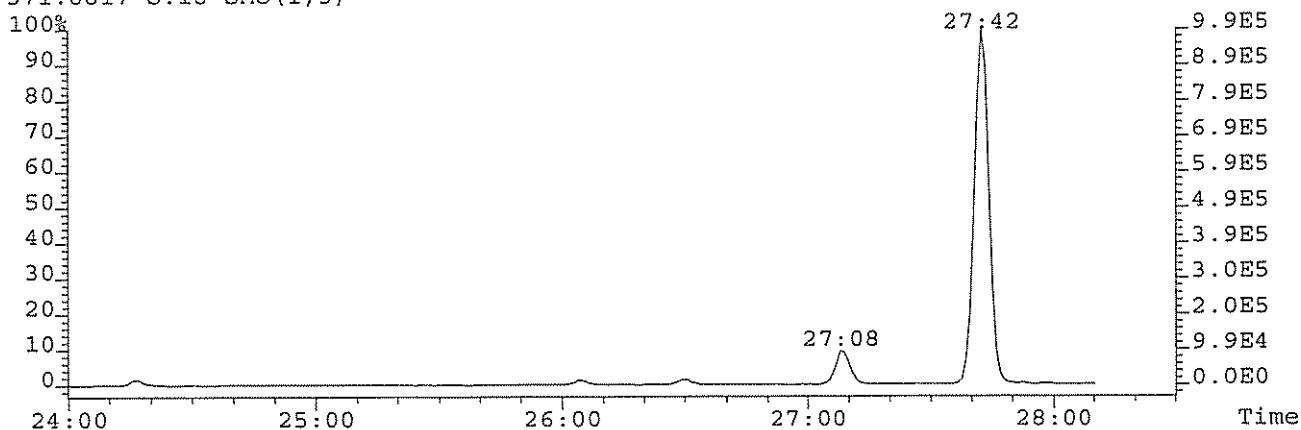
359.8415 S:18 SMO(1,3)



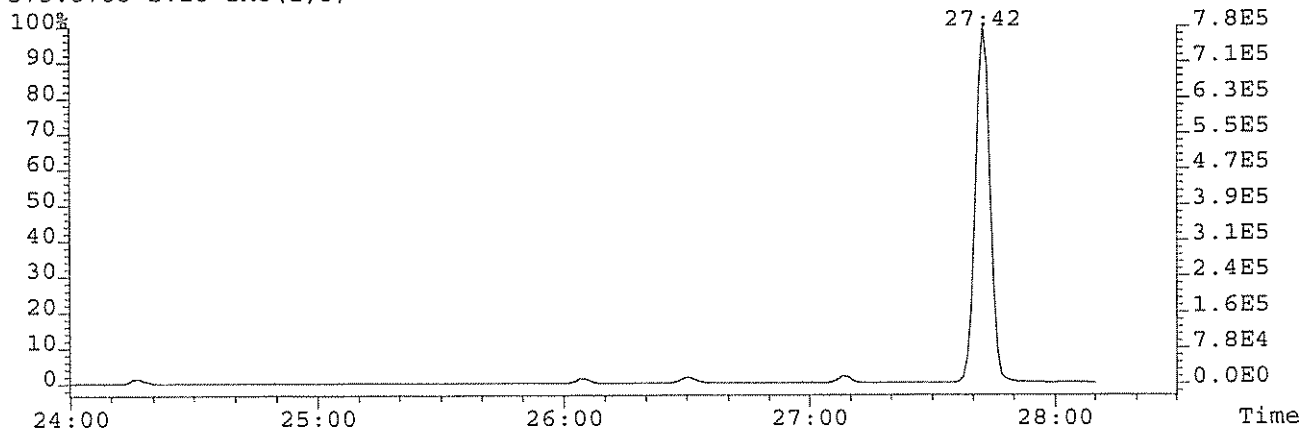
361.8385 S:18 SMO(1,3)



371.8817 S:18 SMO(1,3)

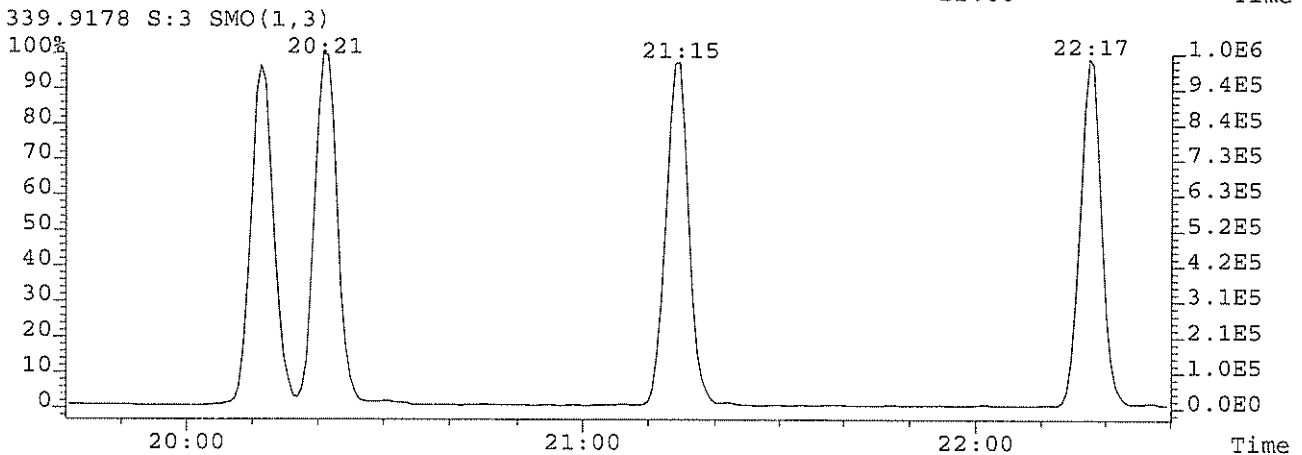
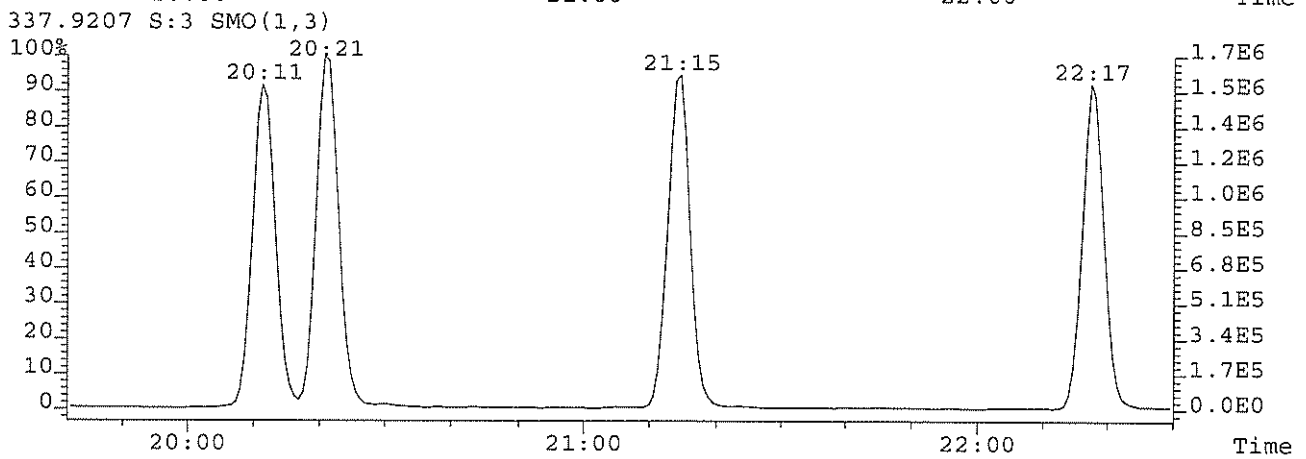
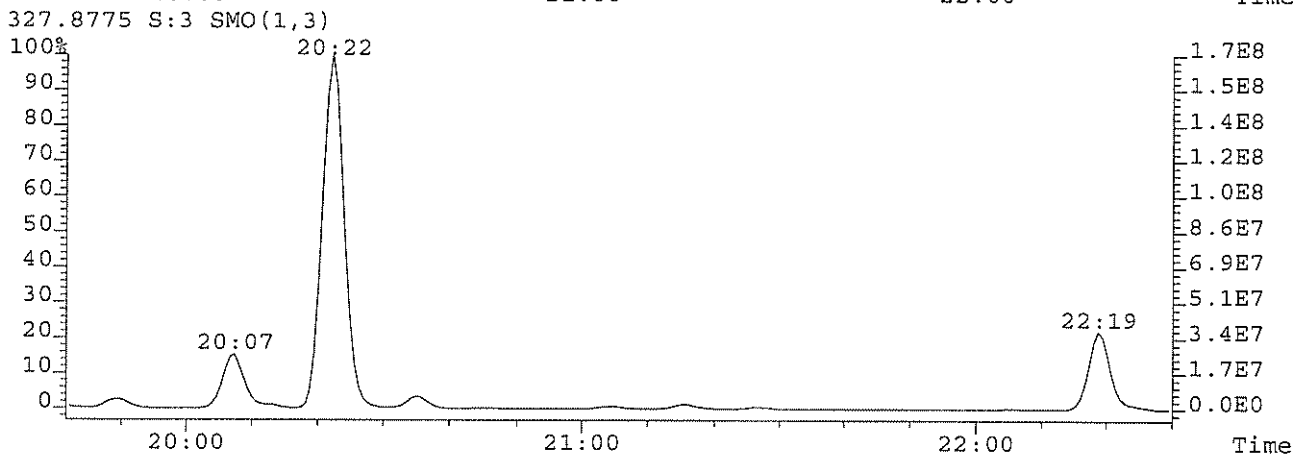
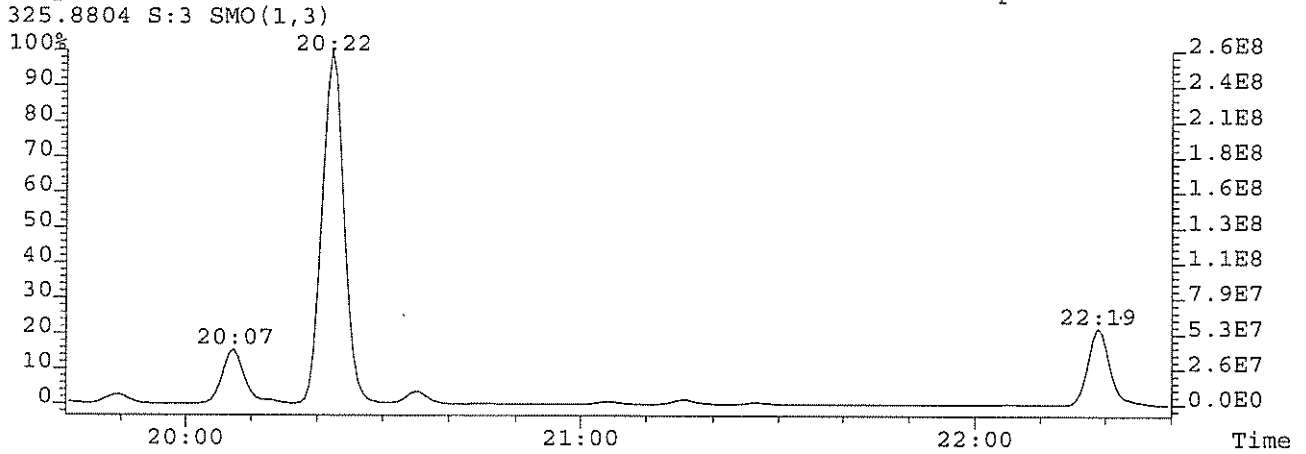


373.8788 S:18 SMO(1,3)



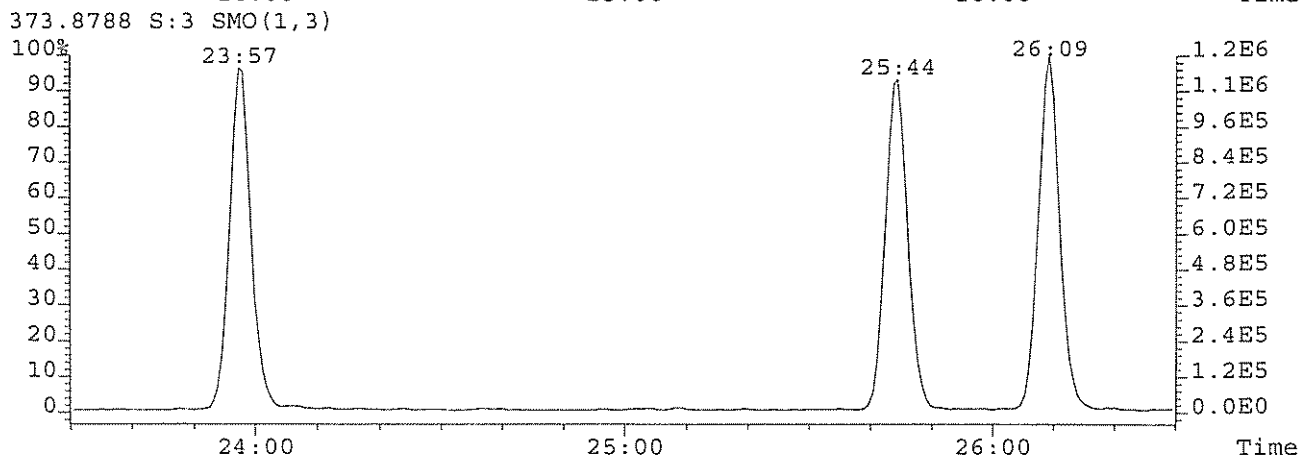
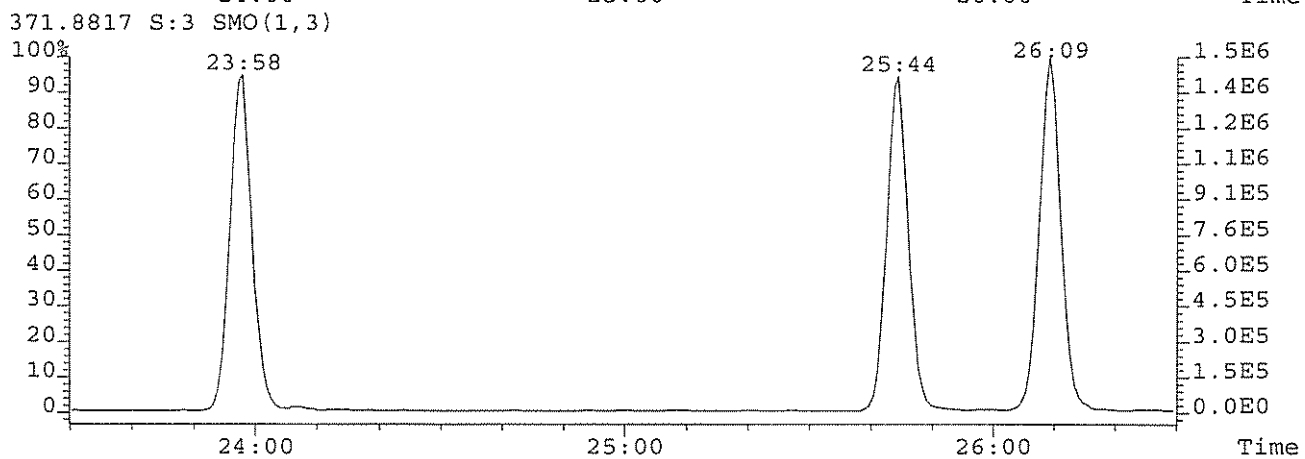
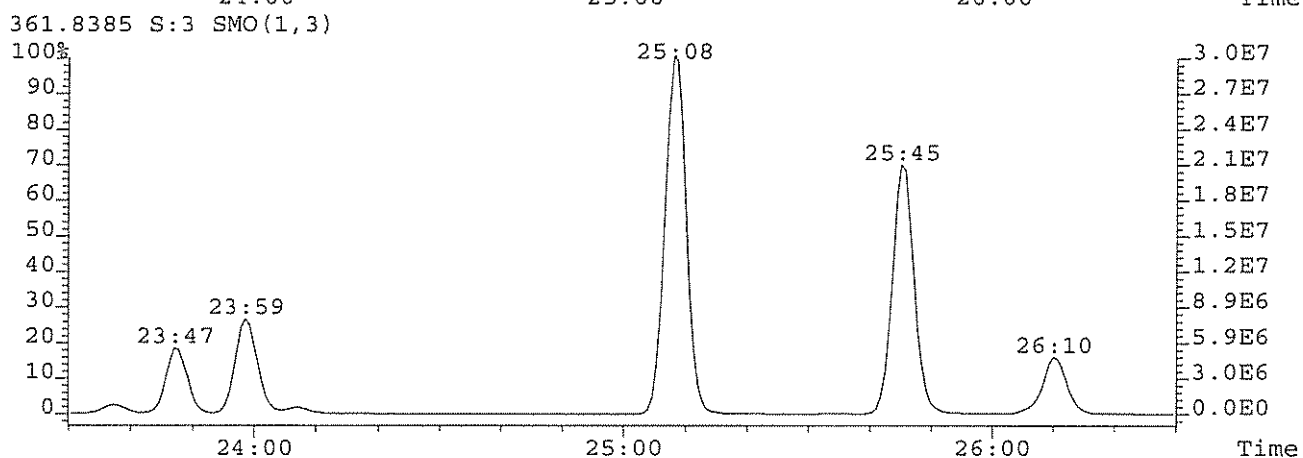
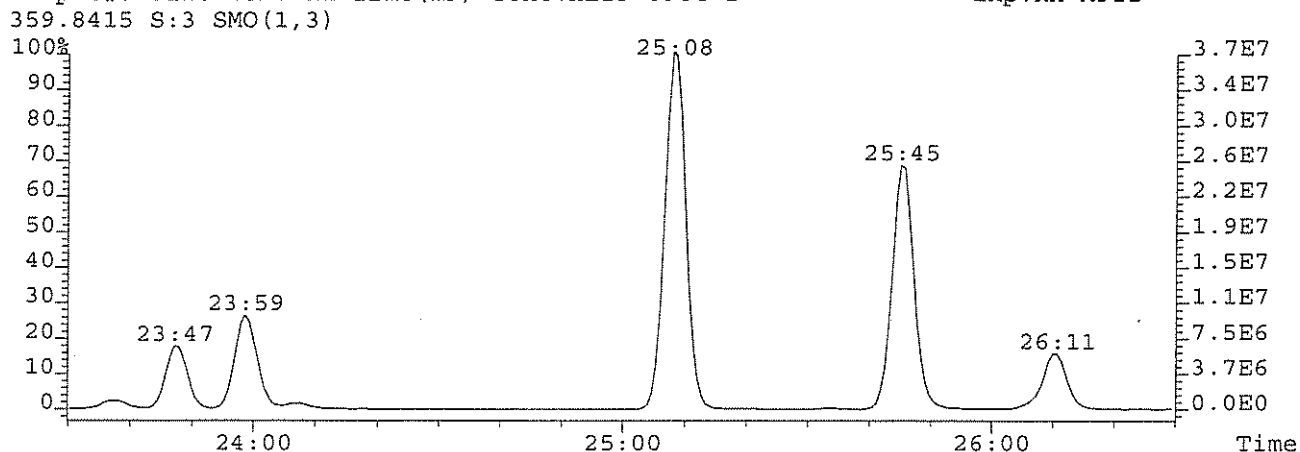
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130716-2 #1-2898 Acq:16-JUL-2013 15:59:46 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#3 File Text:RH-12ms(mP) Text:XE13 0964 2 Exp:RH-MP11



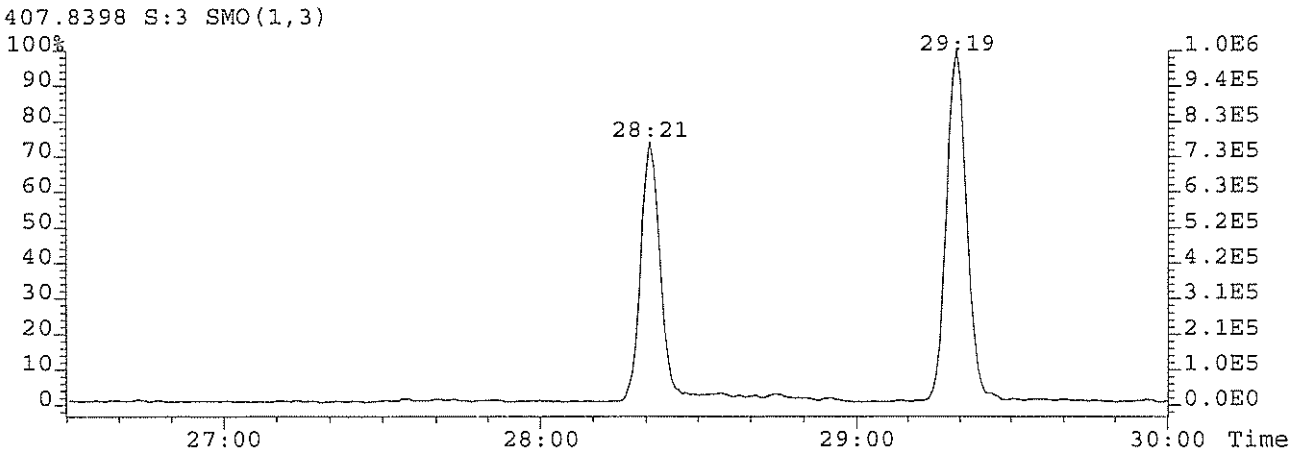
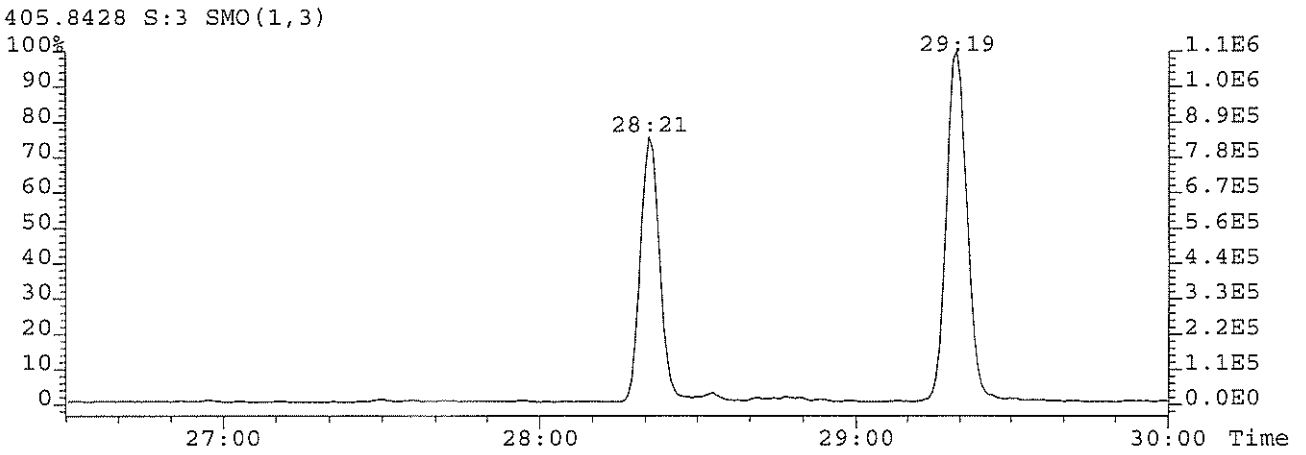
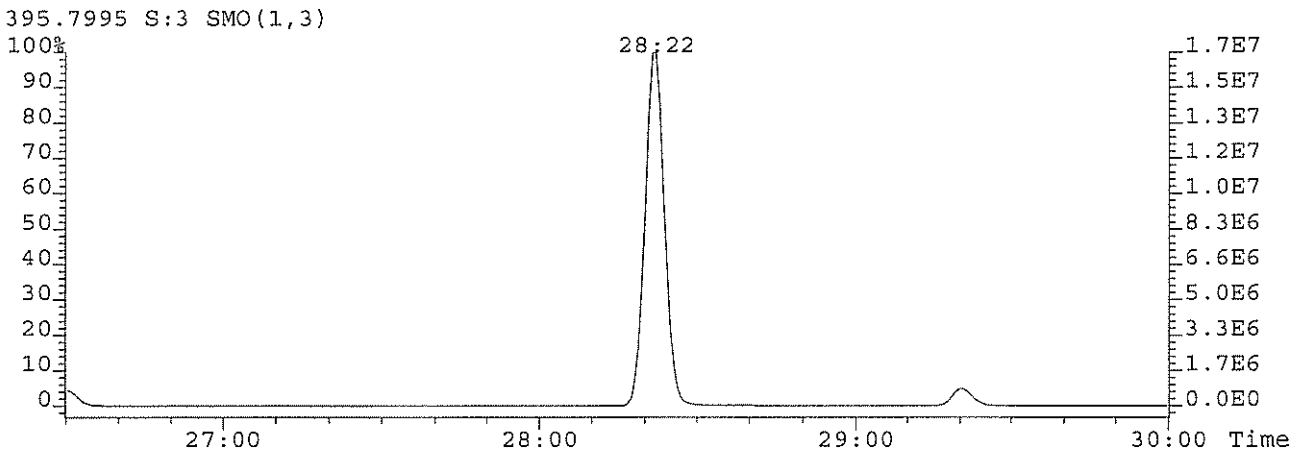
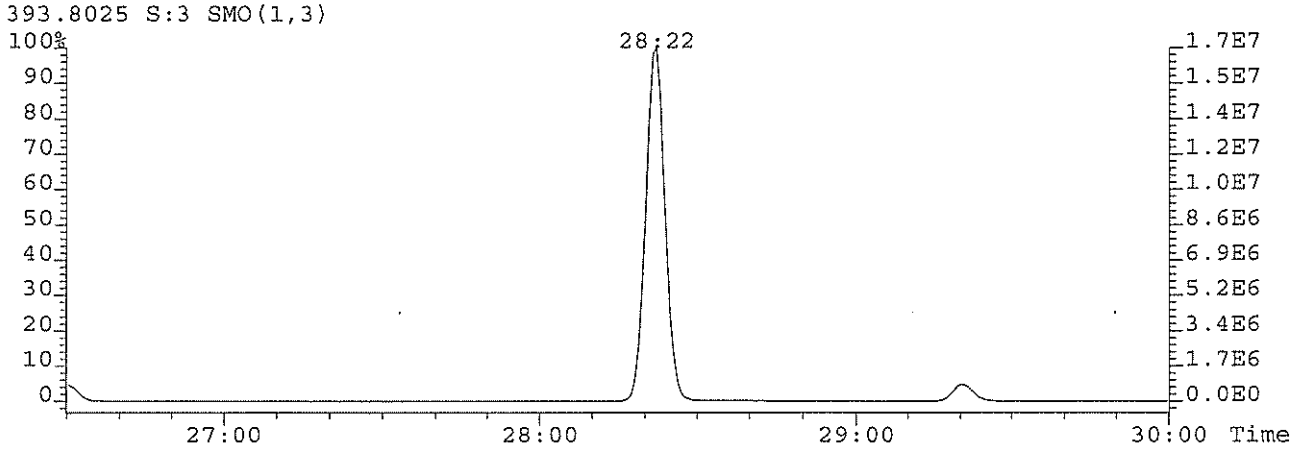
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130716-2 #1-2898 Acq:16-JUL-2013 15:59:46 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#3 File Text:RH-12ms(mP) Text:XE13 0964 2 Exp:RH-MP11



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

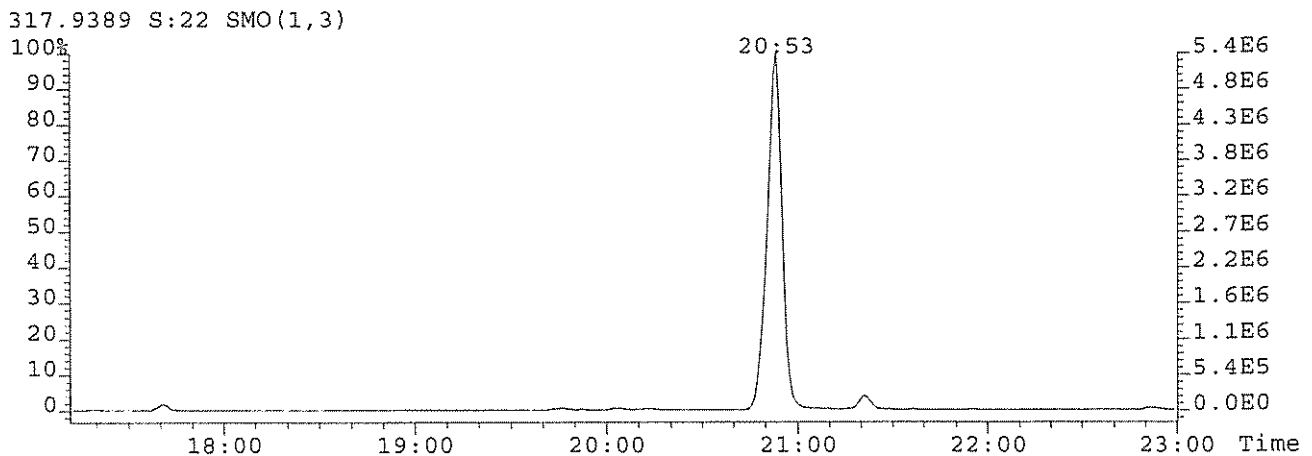
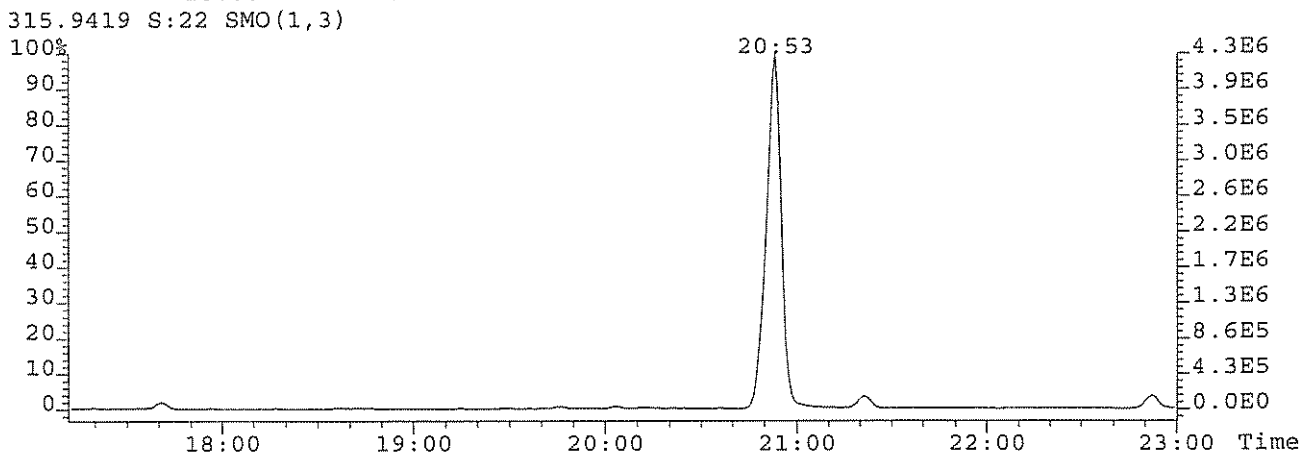
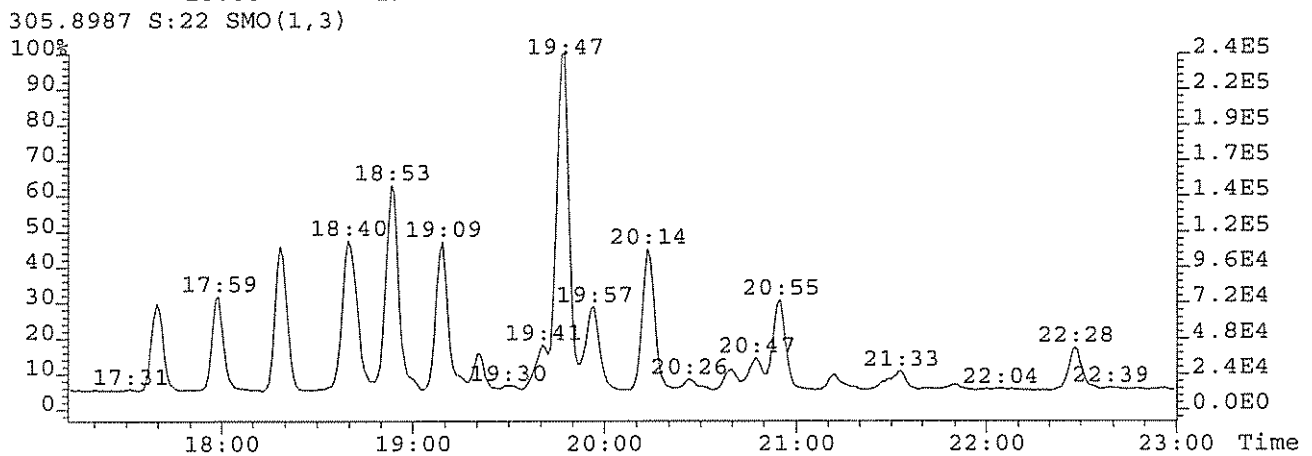
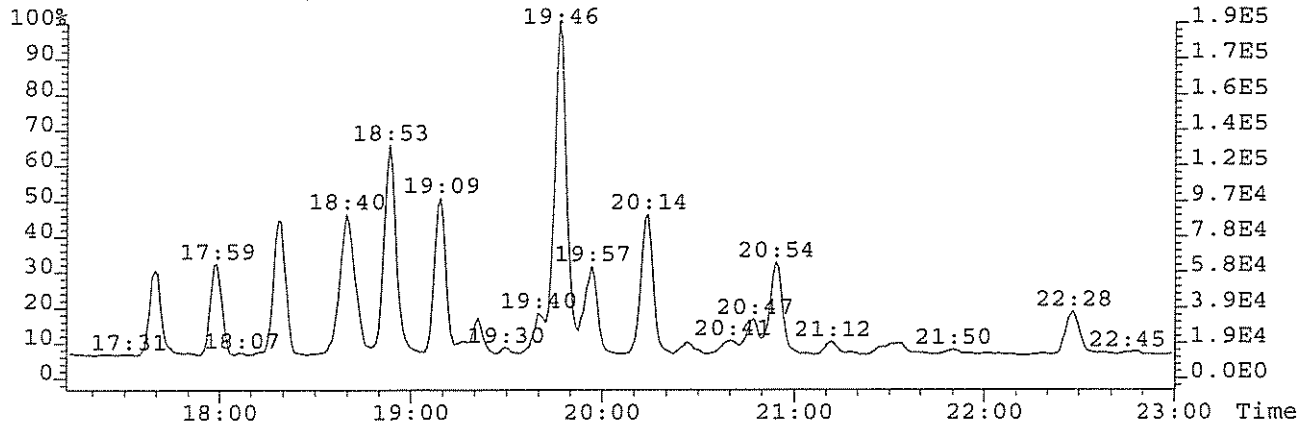
File:130716-2 #1-2898 Acq:16-JUL-2013 15:59:46 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#3 File Text:RH-12ms(mP) Text:XE13 0964 2 Exp:RH-MP11



DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

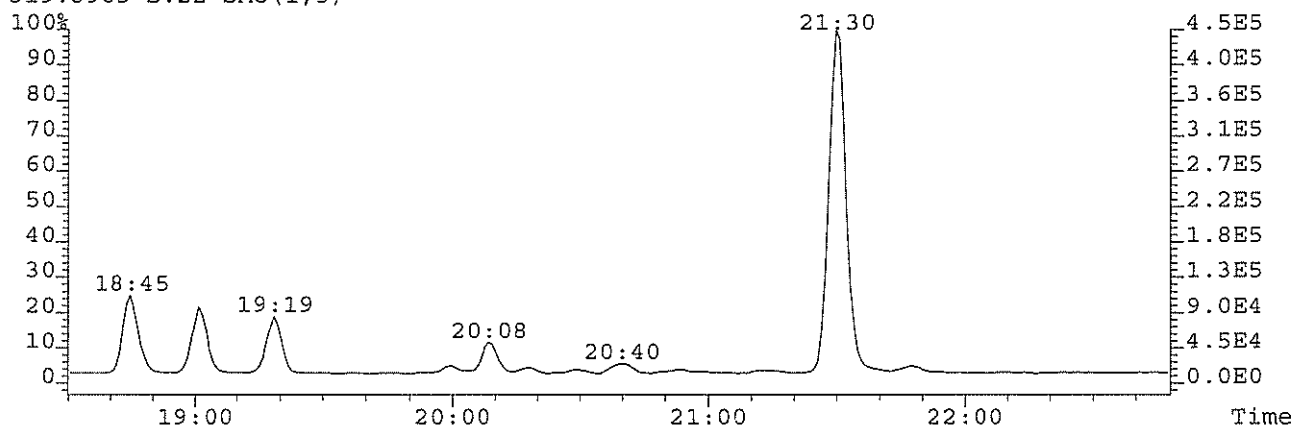
試料管理番号	XE 130965
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.19

File:130712-2 #1-1577 Acq:13-JUL-2013 08:46:33 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:BPX-DXN(4-6DXN) Text:XE13 0965 Exp:BPX04  
303.9016 S:22 SMO(1,3)

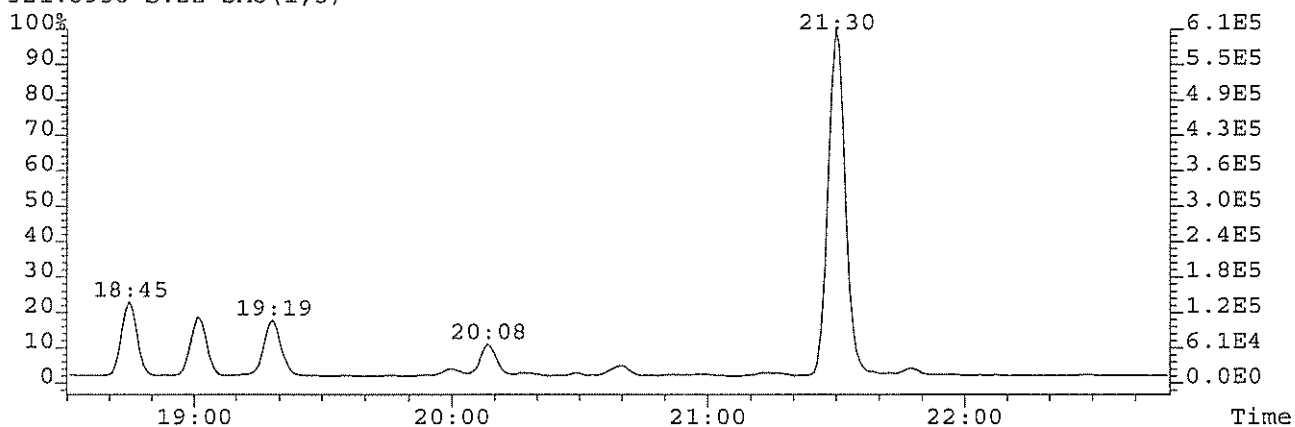


PCDFsクロマトグラム (1)  
(TeCDFs)

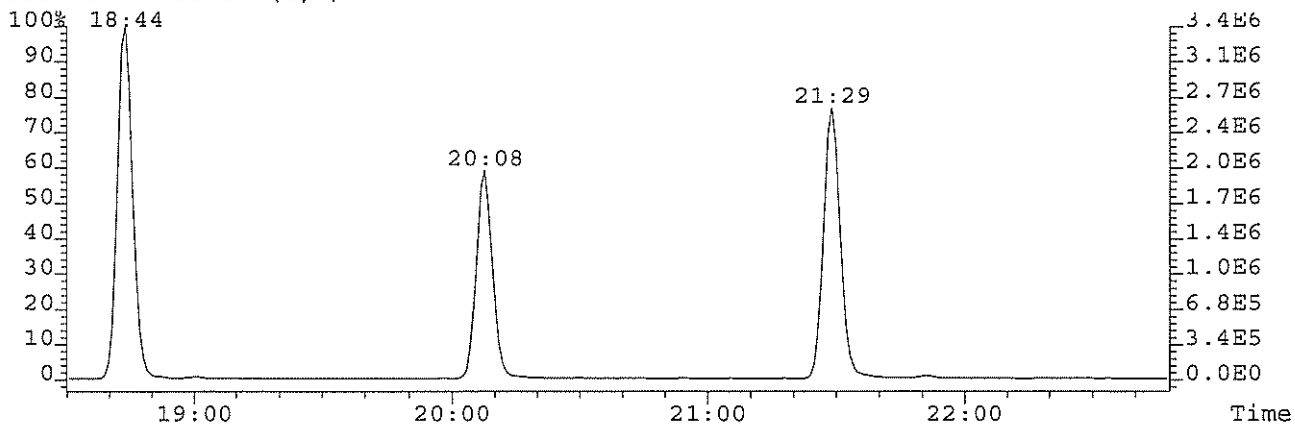
File:130712-2 #1-1577 Acq:13-JUL-2013 08:46:33 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:BPX-DXN(4-6DXN) Text:XE13 0965 Exp:BPX04  
319.8965 S:22 SMO(1,3)



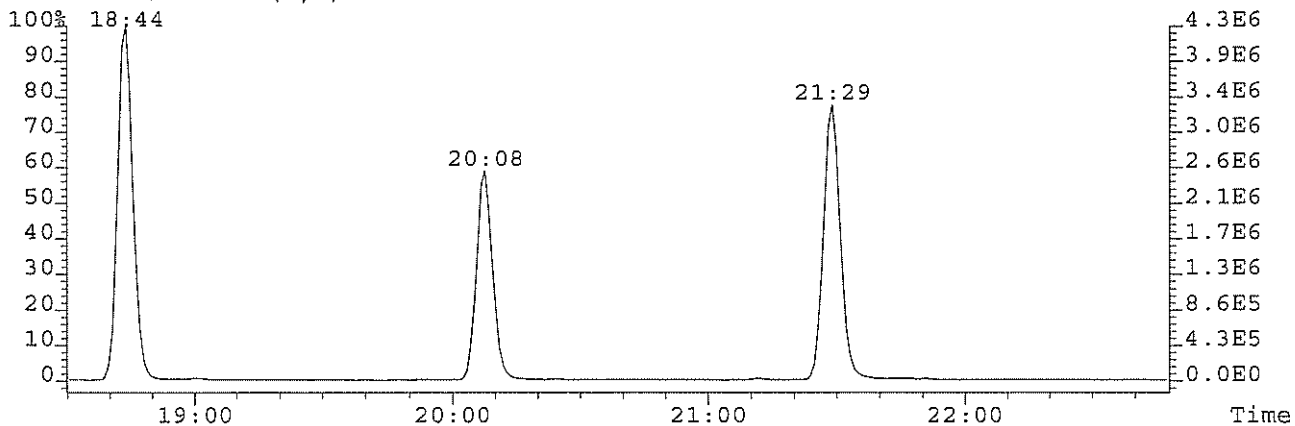
321.8936 S:22 SMO(1,3)



331.9368 S:22 SMO(1,3)

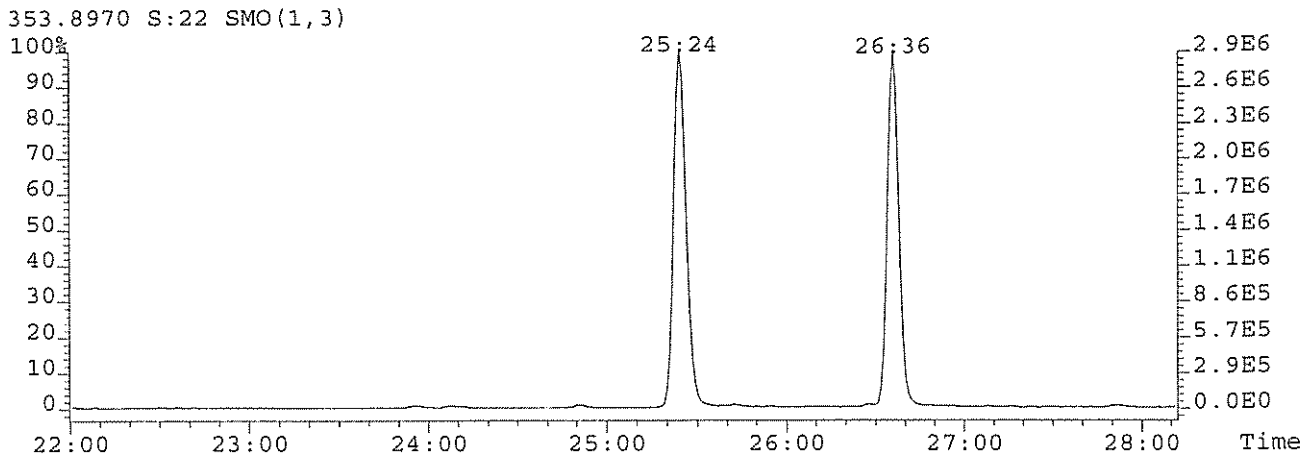
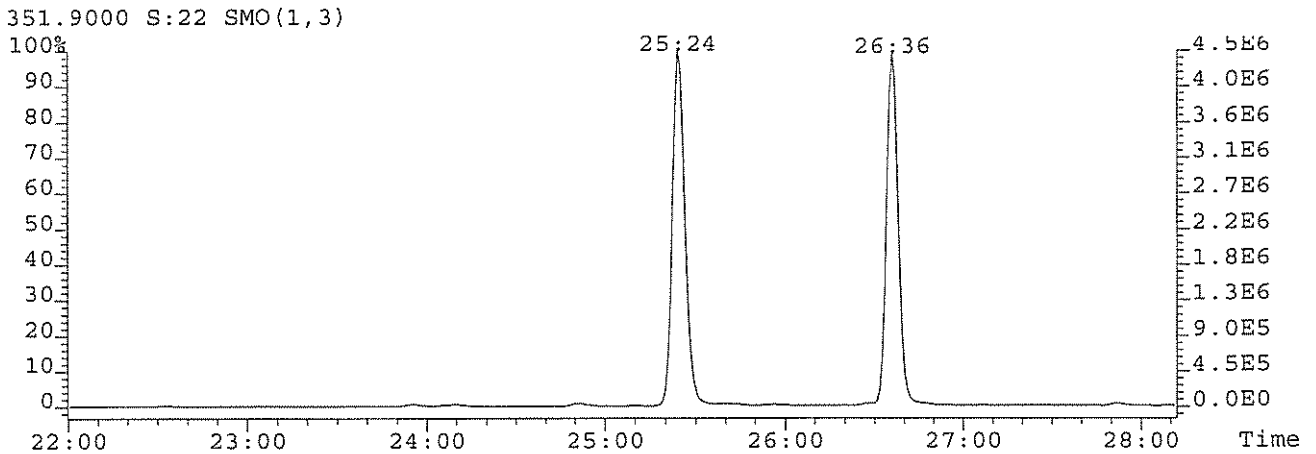
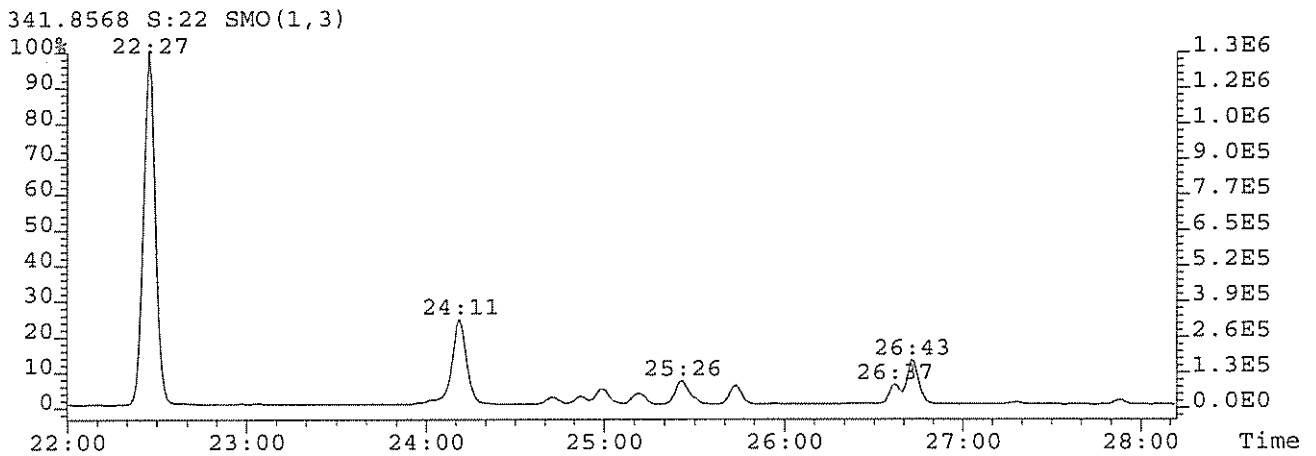
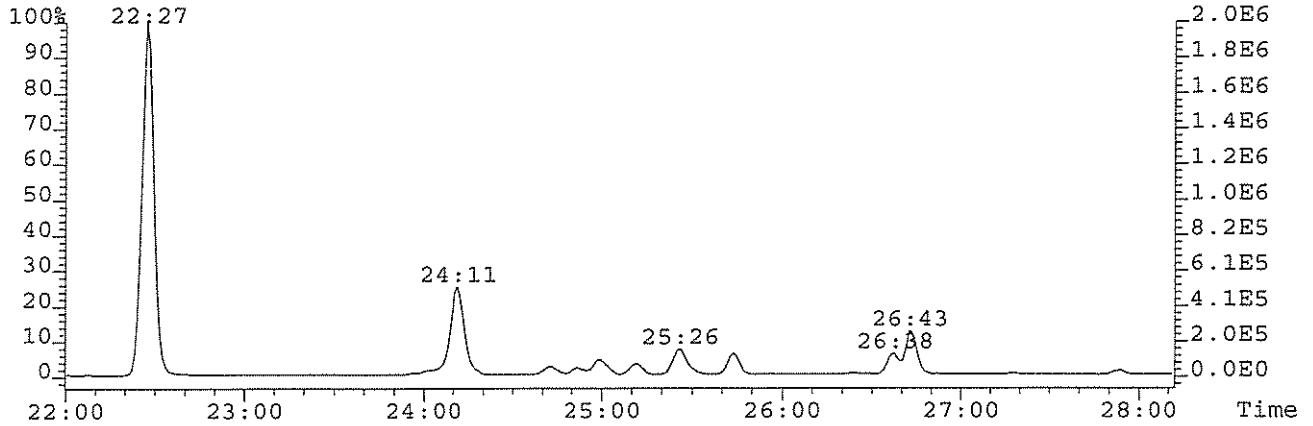


333.9339 S:22 SMO(1,3)



PCDDsクロマトグラム (2)  
(TeCDDs)

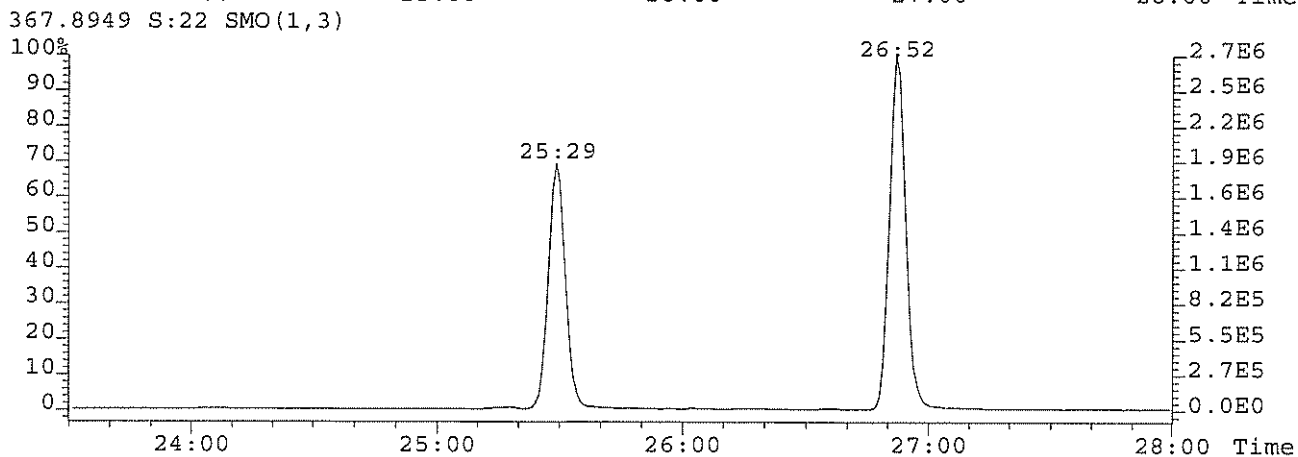
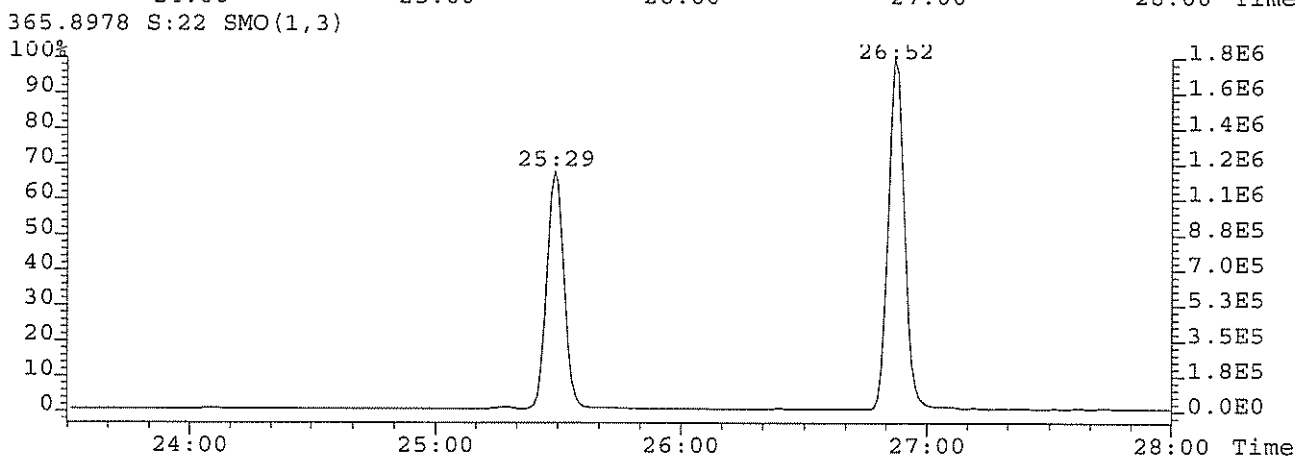
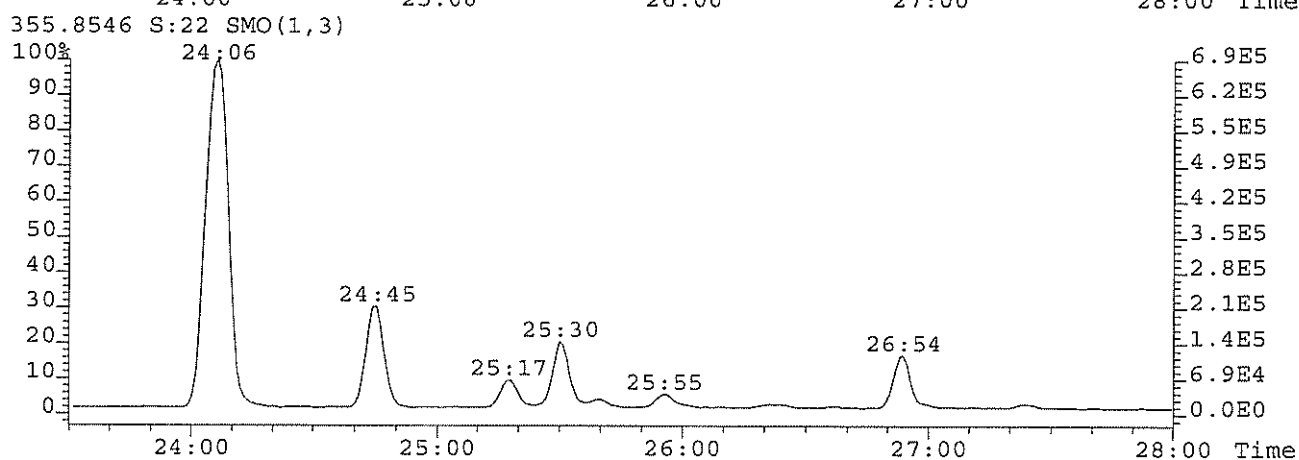
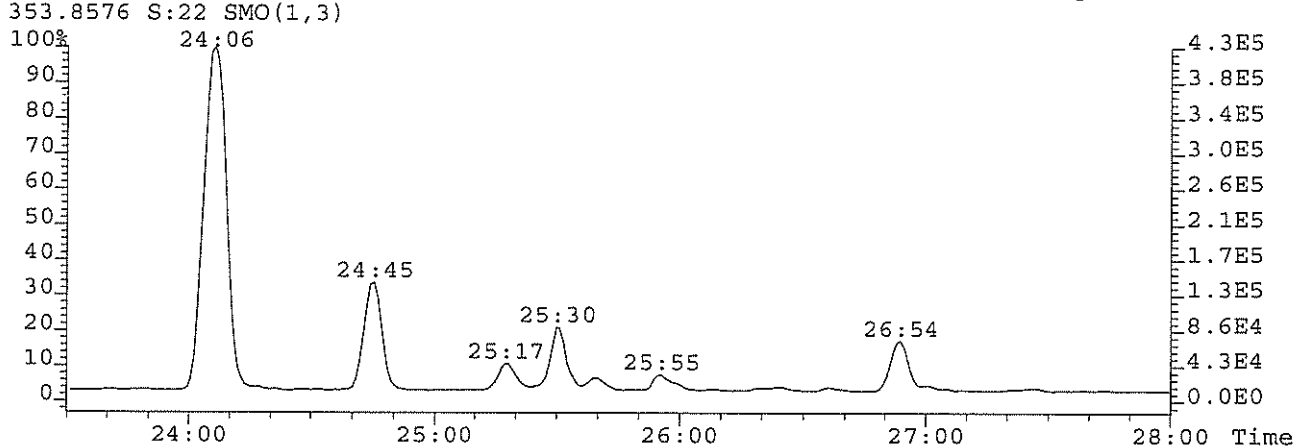
File:130712-2 #1-1577 Acq:13-JUL-2013 08:46:33 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:BPX-DXN(4-6DXN) Text:XE13 0965 Exp:BPX04  
339.8597 S:22 SMO(1,3)



PCDFsクロマトグラム (3)  
(PeCDFs)

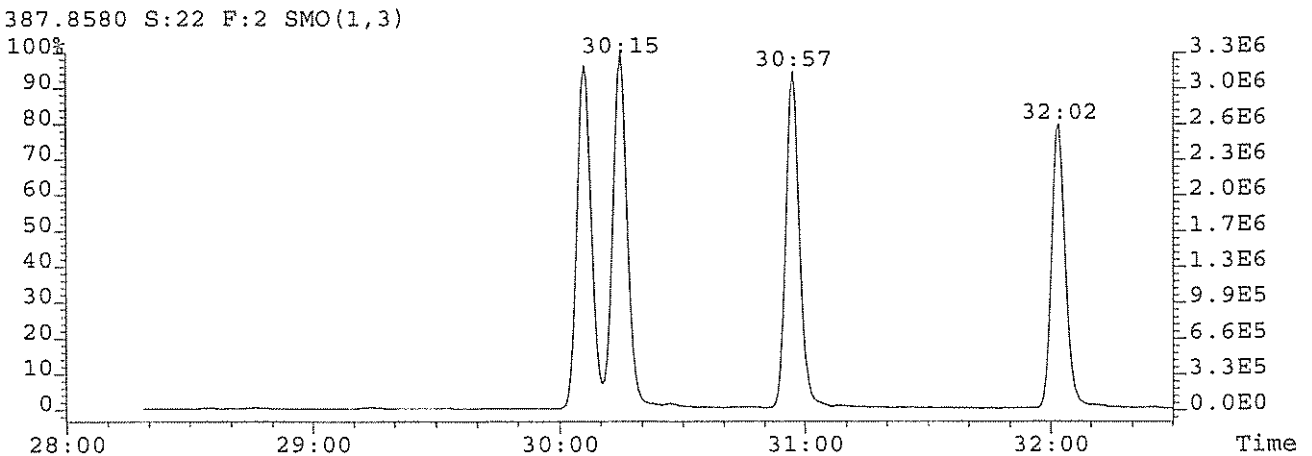
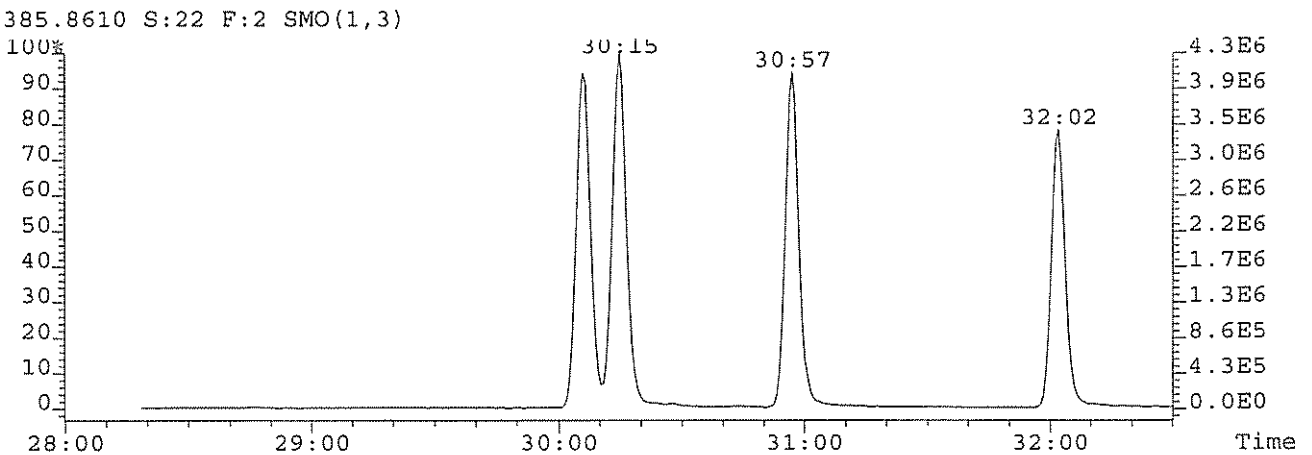
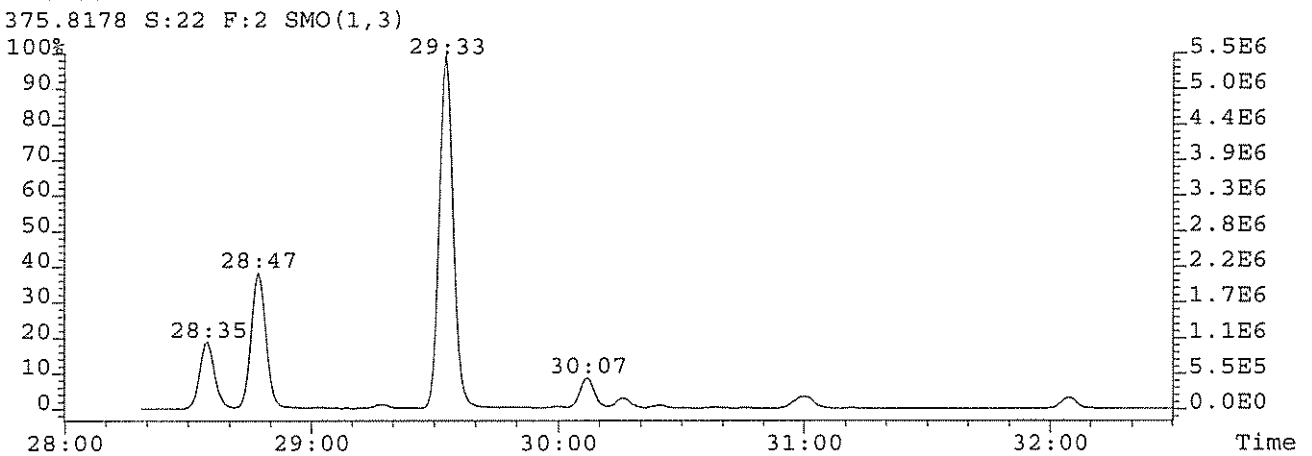
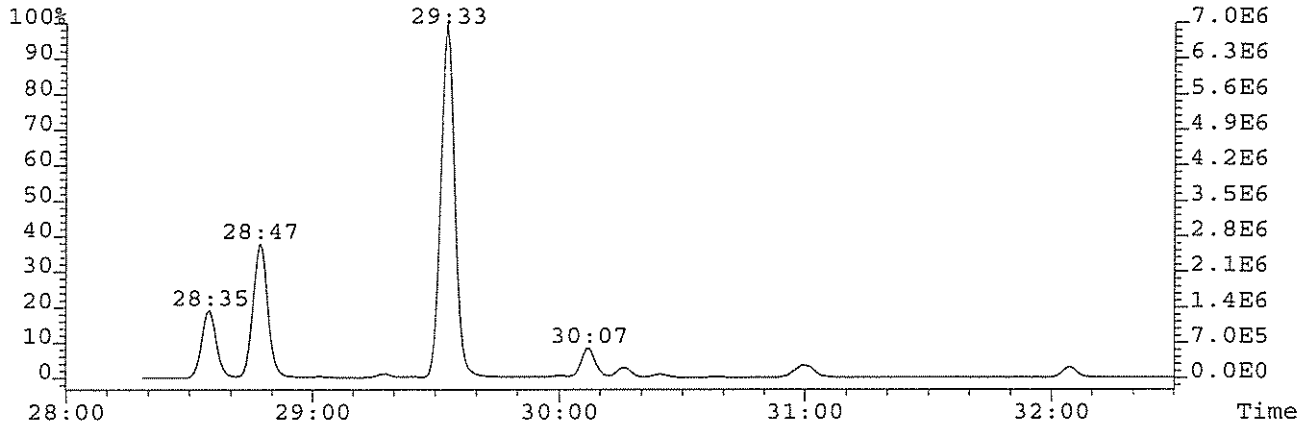


File:130712-2 #1-1577 Acq:13-JUL-2013 08:46:33 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:BPX-DXN(4-6DXN) Text:XE13 0965 Exp:BPX04



PCDDsクロマトグラム (4)  
(PeCDDs)

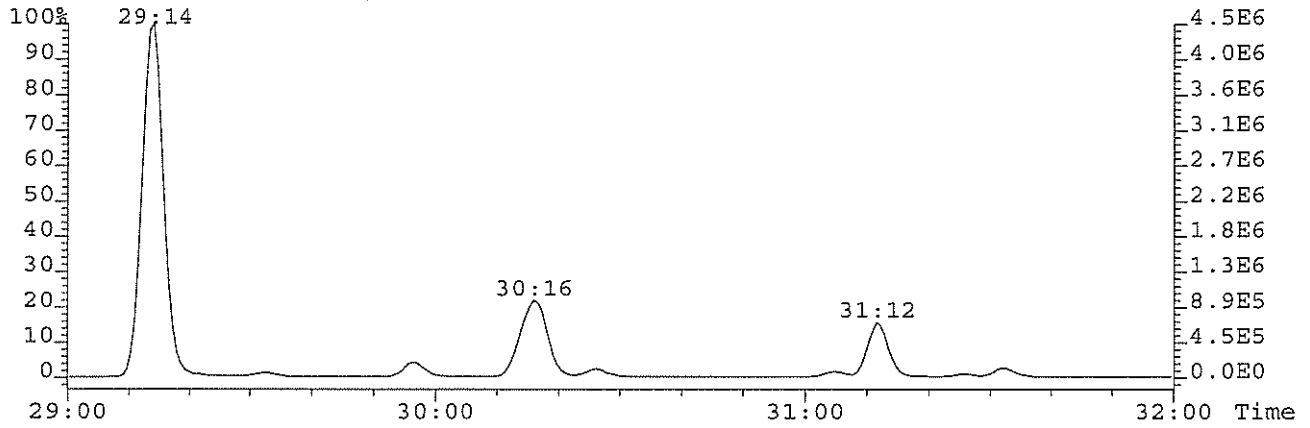
File:130712-2 #1-1117 Acq:13-JUL-2013 08:46:33 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:BPX-DXN(4-6DXN) Text:XE13 0965 Exp:BPX04  
373.8207 S:22 F:2 SMO(1,3)



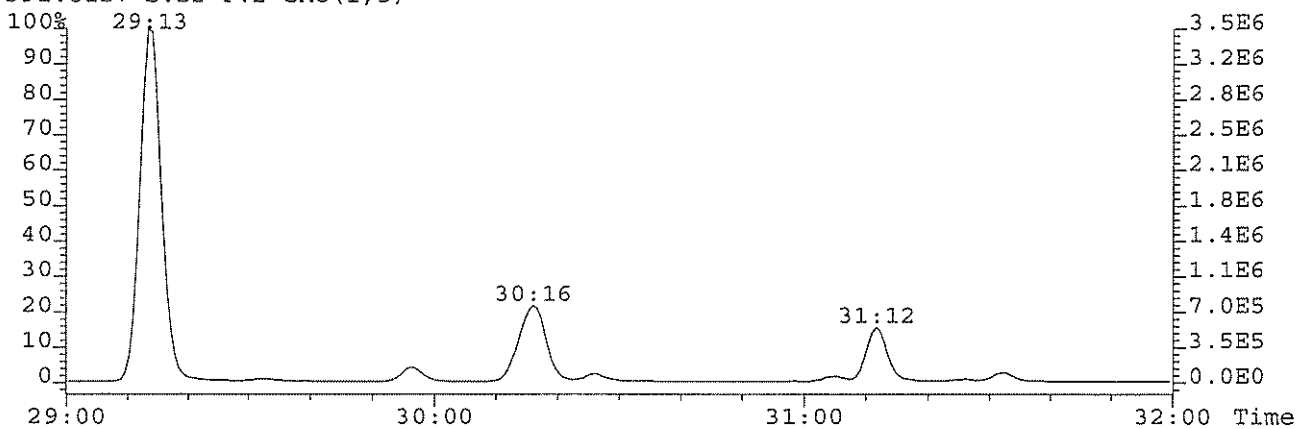
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1117 Acq:13-JUL-2013 08:46:33 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:BPX-DXN(4-6DXN) Text:XE13 0965 Exp:BPX04

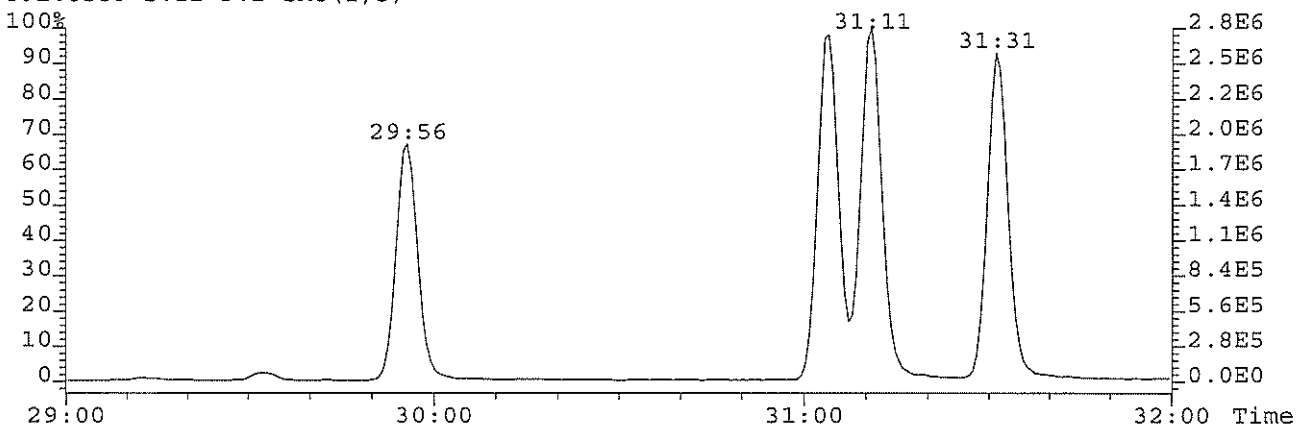
389.8156 S:22 F:2 SMO(1,3)



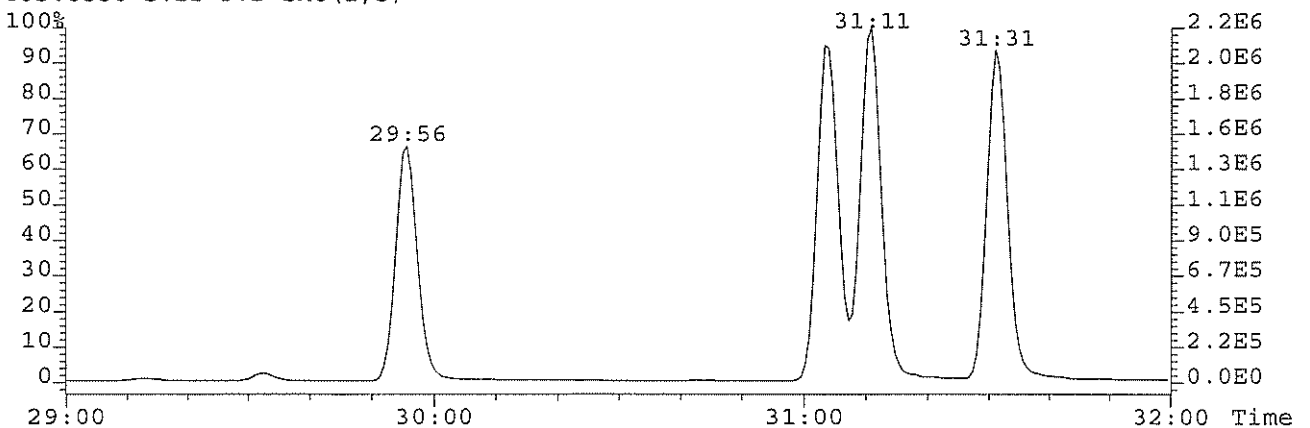
391.8127 S:22 F:2 SMO(1,3)



401.8559 S:22 F:2 SMO(1,3)

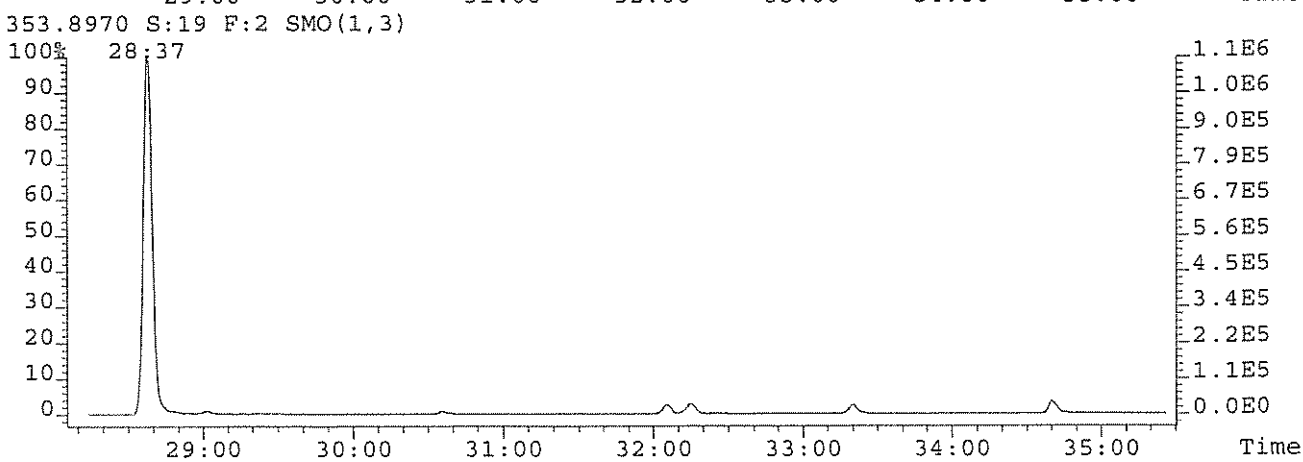
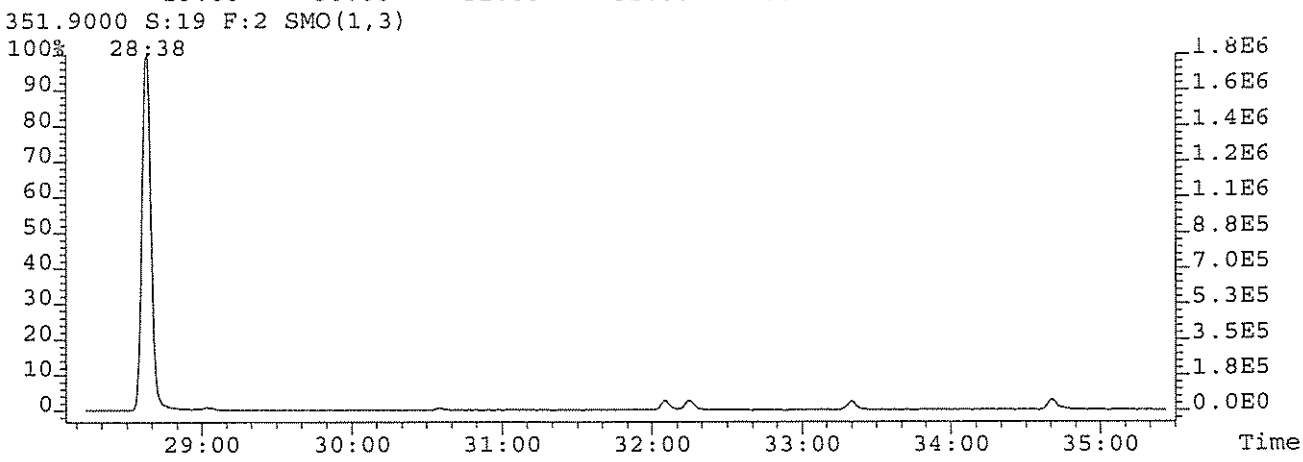
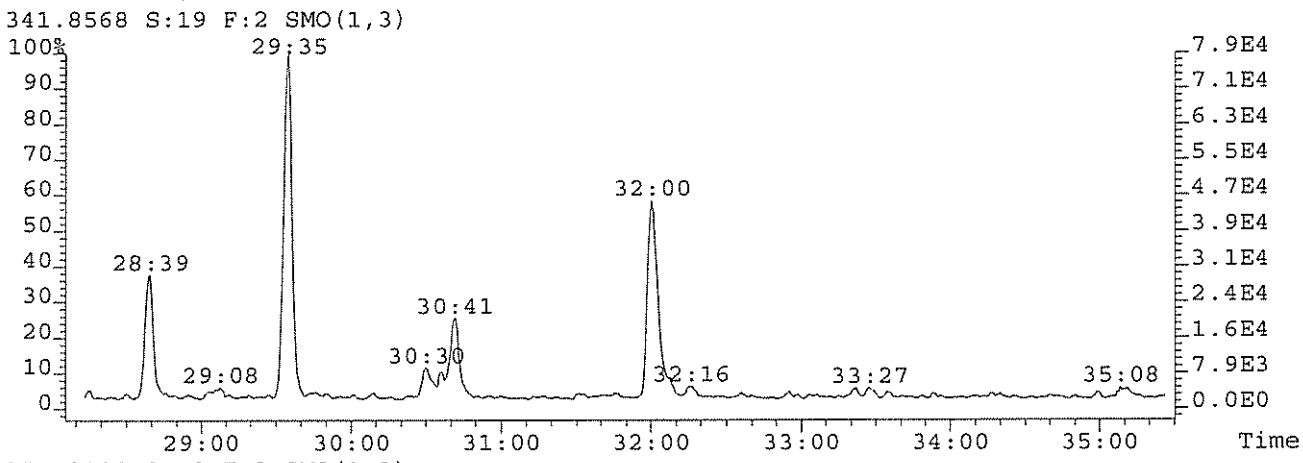
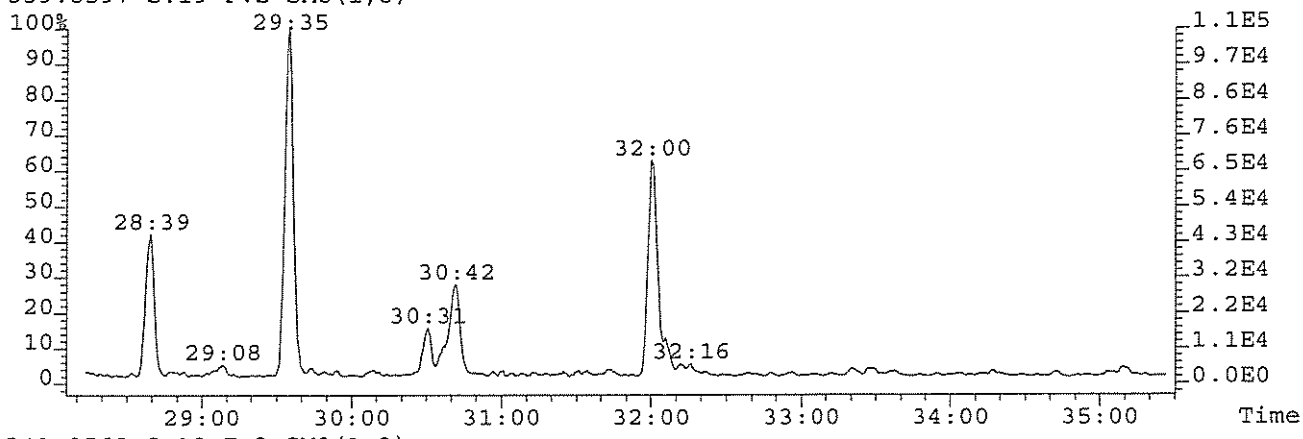


403.8530 S:22 F:2 SMO(1,3)



PCDDsクロマトグラム (6)  
(HxCDDs)

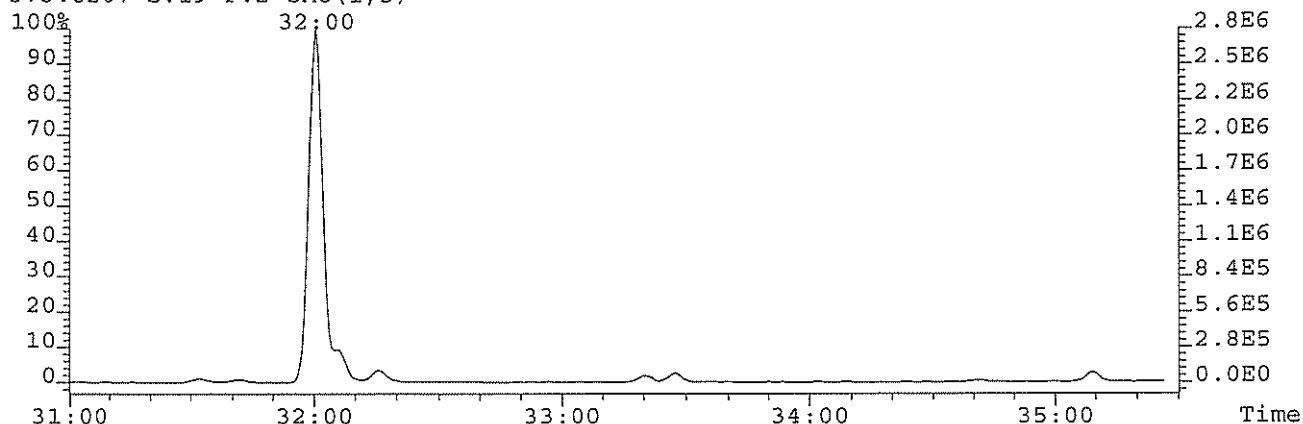
File:130713 #1-648 Acq:14-JUL-2013 03:05:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0965 3 Exp:RH-PD22  
339.8597 S:19 F:2 SMO(1,3)



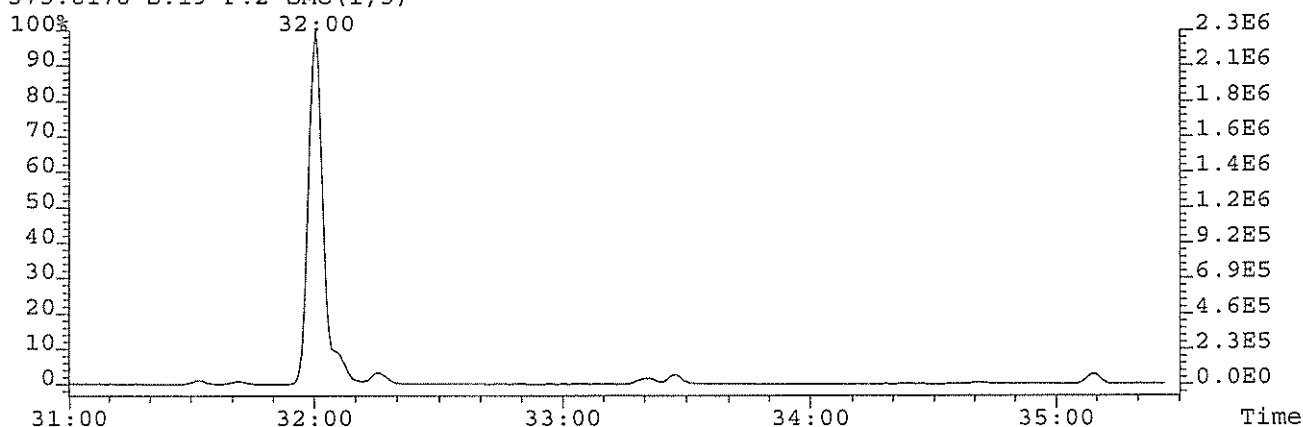
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130713 #1-648 Acq:14-JUL-2013 03:05:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0965 3 Exp:RH-PD22

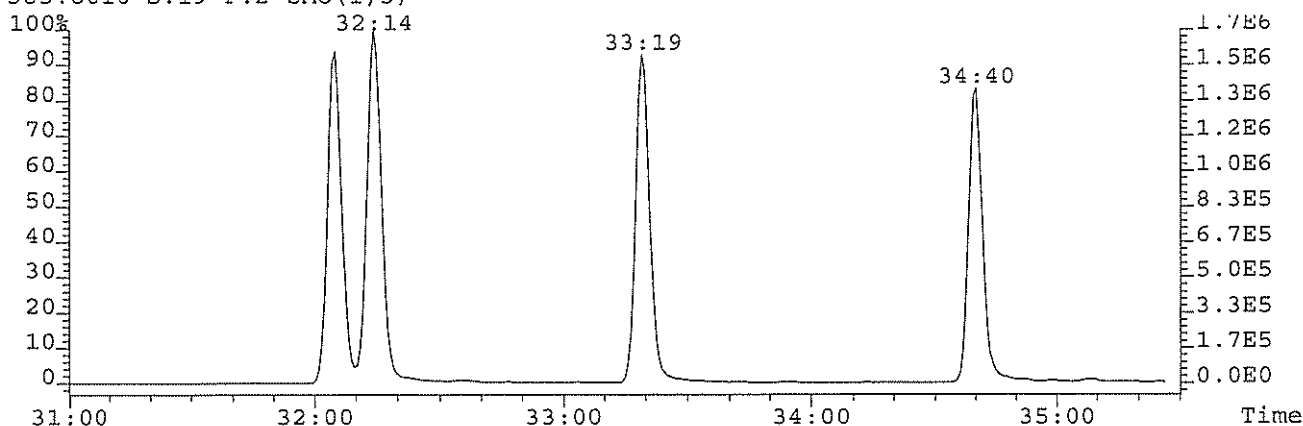
373.8207 S:19 F:2 SMO(1,3)



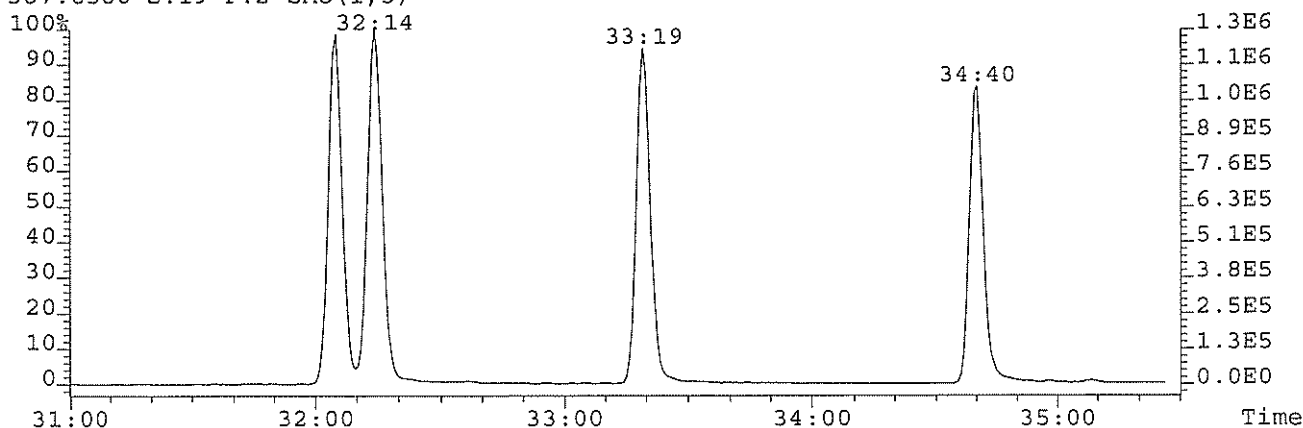
375.8178 S:19 F:2 SMO(1,3)



385.8610 S:19 F:2 SMO(1,3)

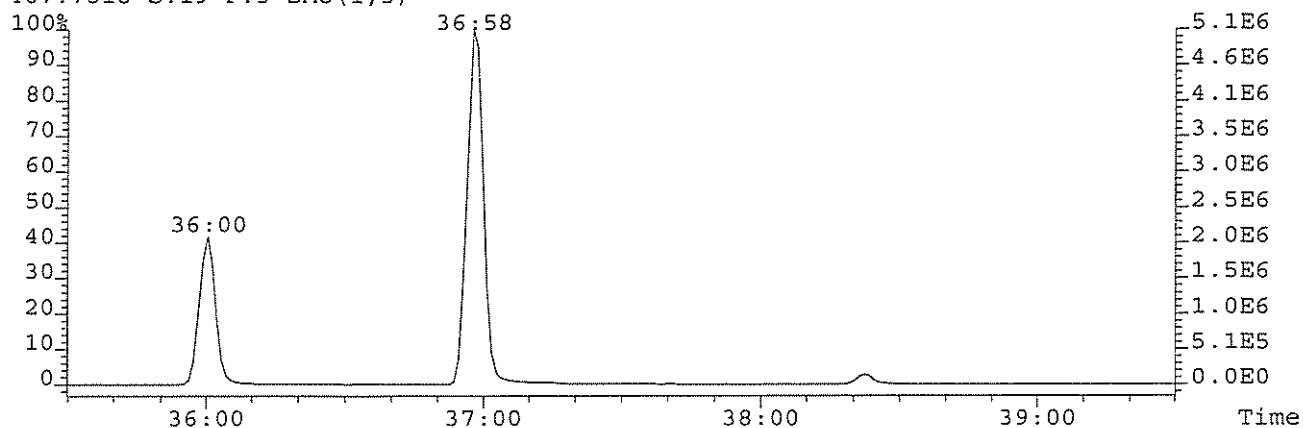


387.8580 S:19 F:2 SMO(1,3)

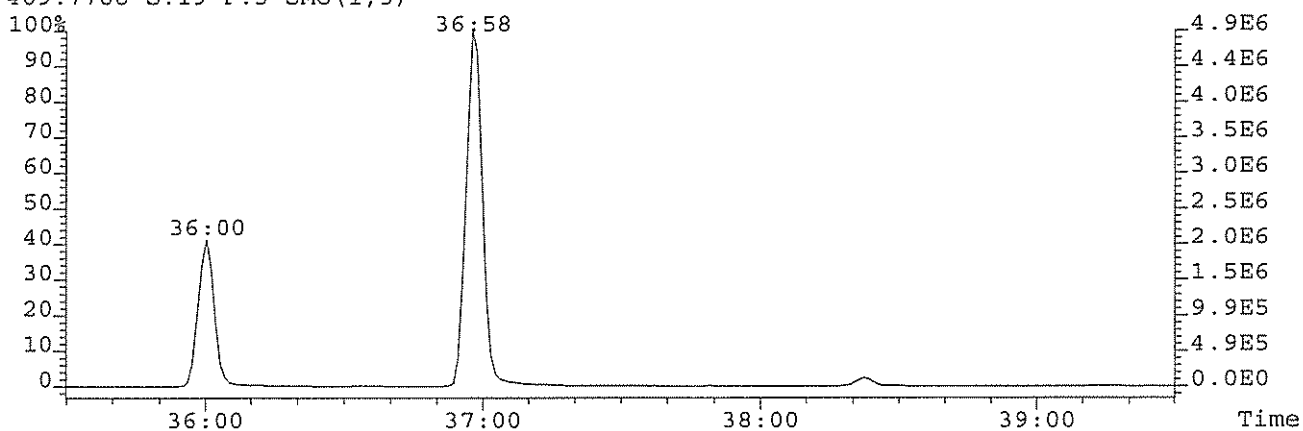


HxCDFsクロマトグラム (8)  
(123789-HxCDF)

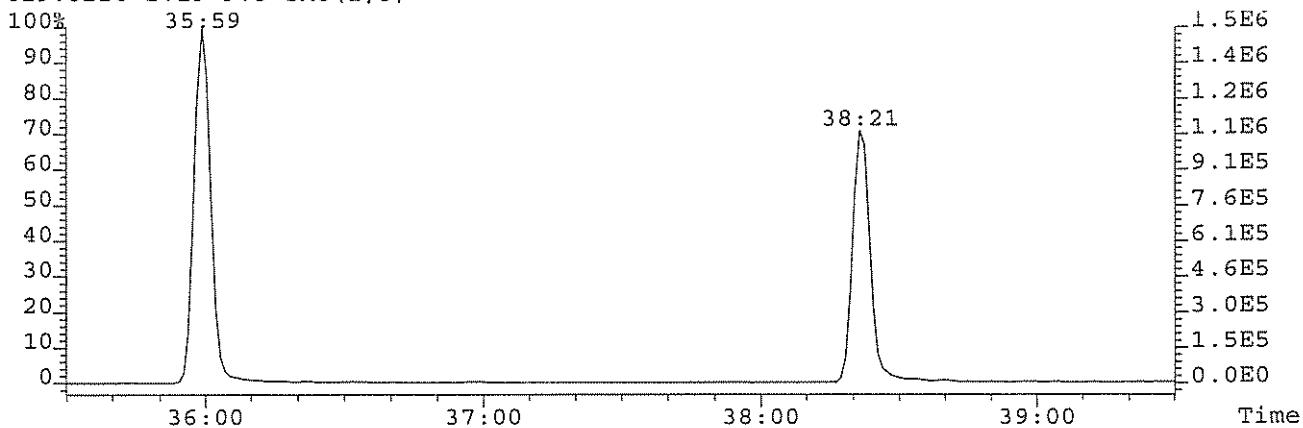
File:130713 #1-561 Acq:14-JUL-2013 03:05:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0965 3 Exp:RH-PD22  
407.7818 S:19 F:3 SMO(1,3)



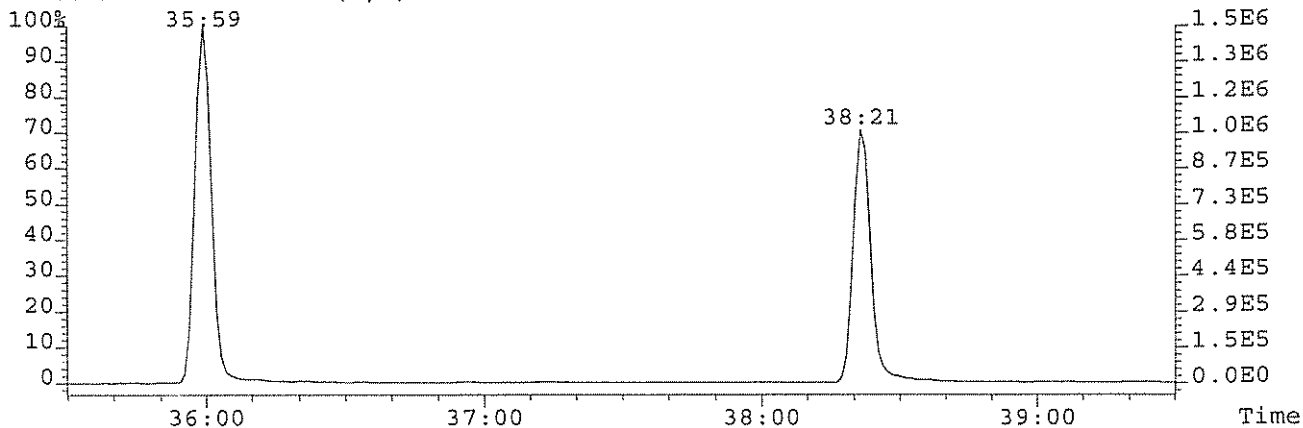
409.7788 S:19 F:3 SMO(1,3)



419.8220 S:19 F:3 SMO(1,3)

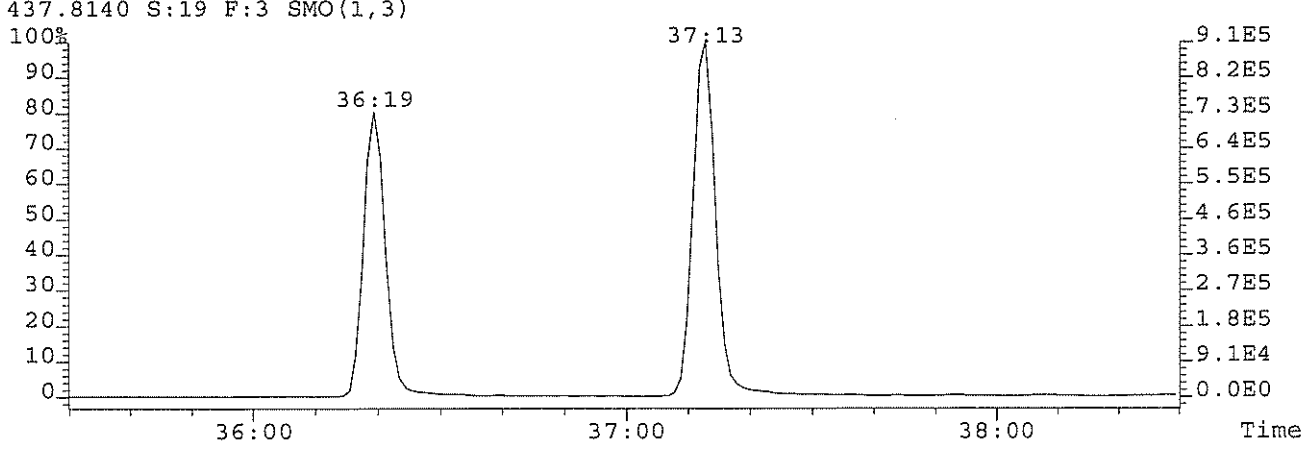
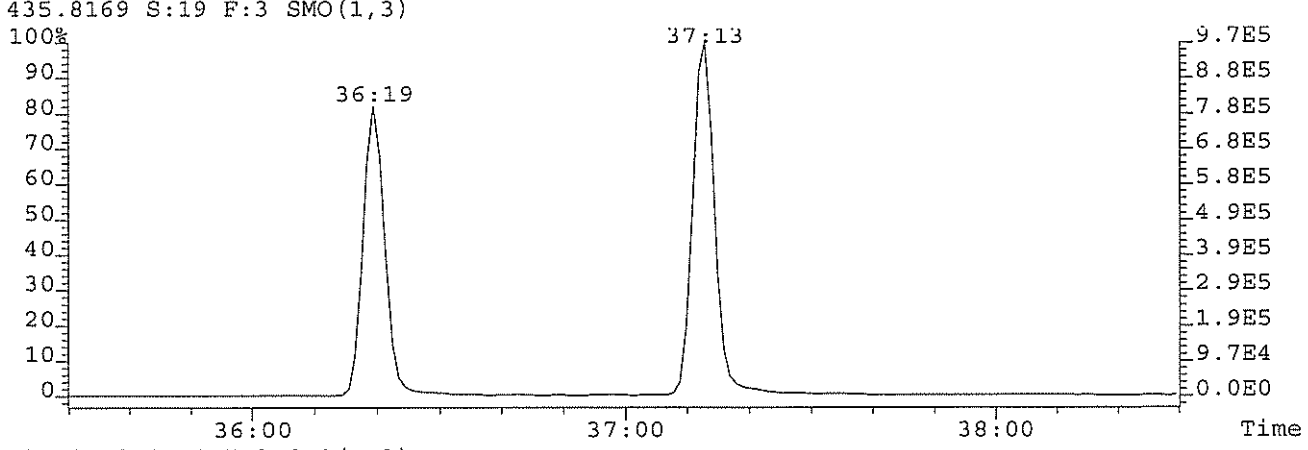
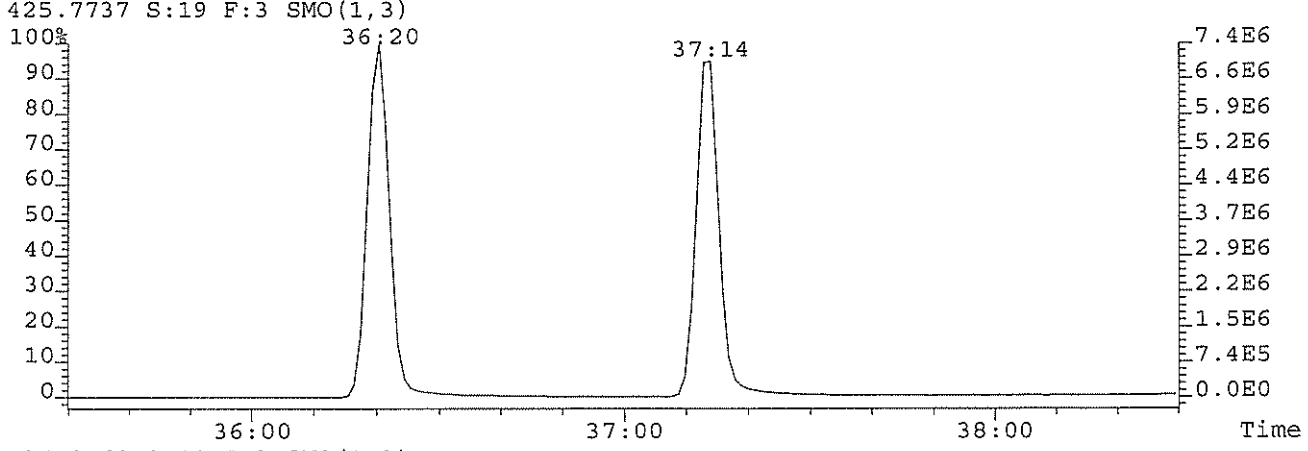
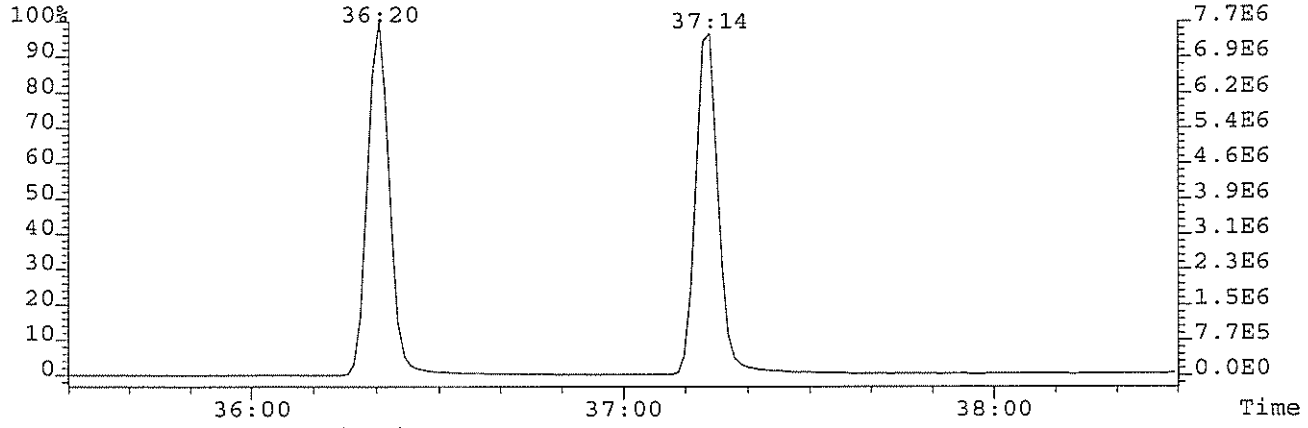


421.8191 S:19 F:3 SMO(1,3)



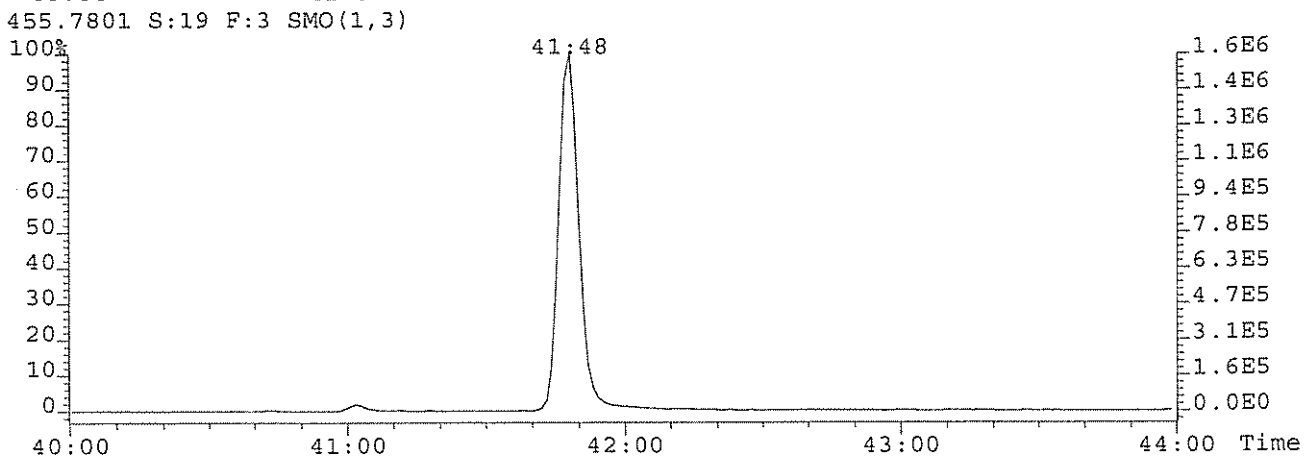
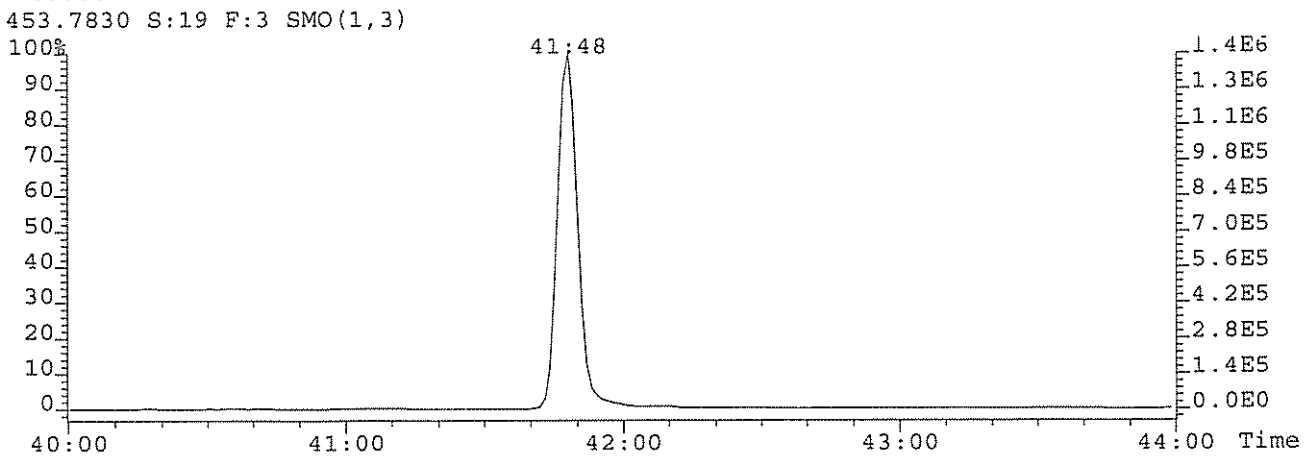
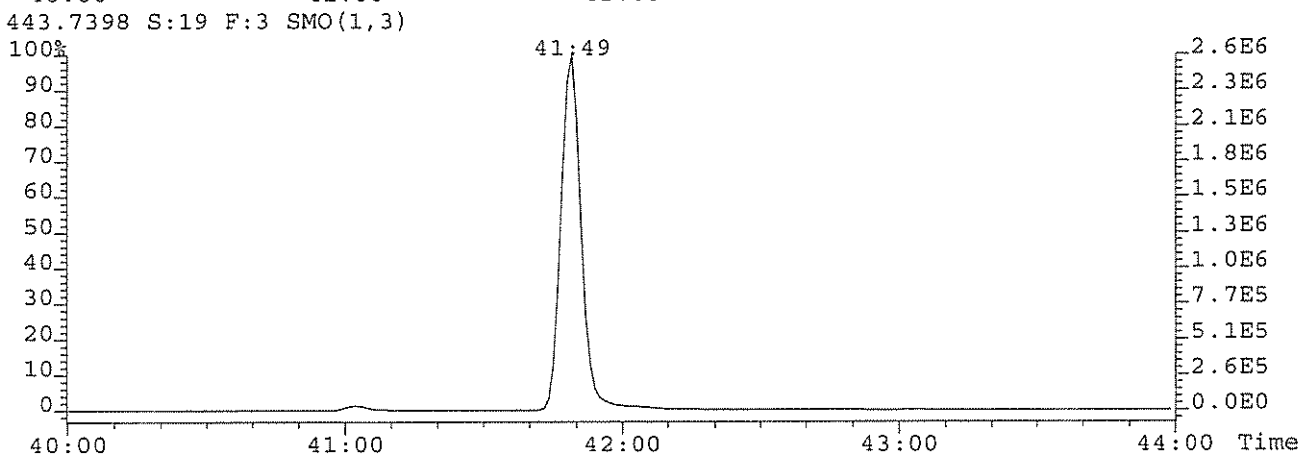
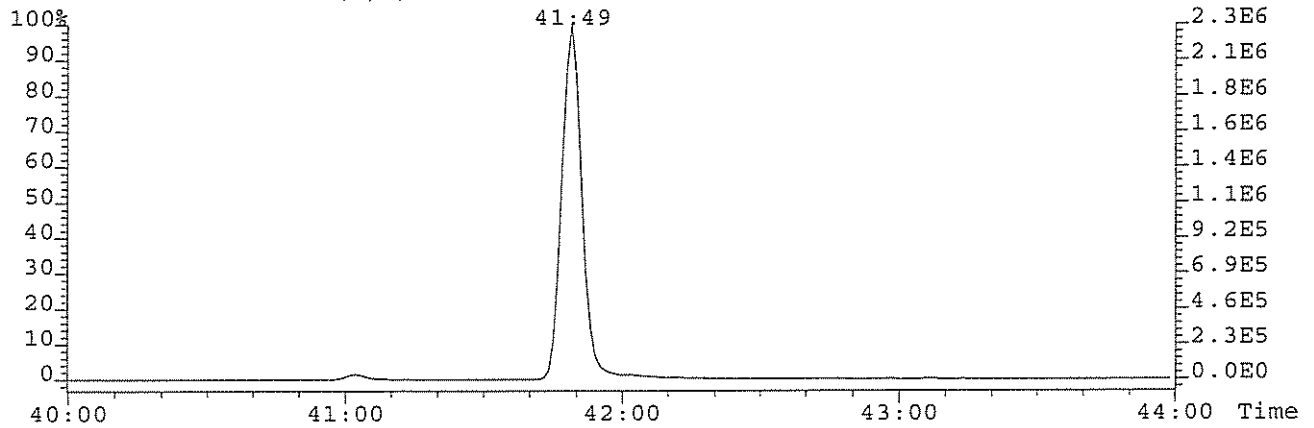
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130713 #1-561 Acq:14-JUL-2013 03:05:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0965 3 Exp:RH-PD22



PCDDsクロマトグラム (10)  
(HpCDDs)

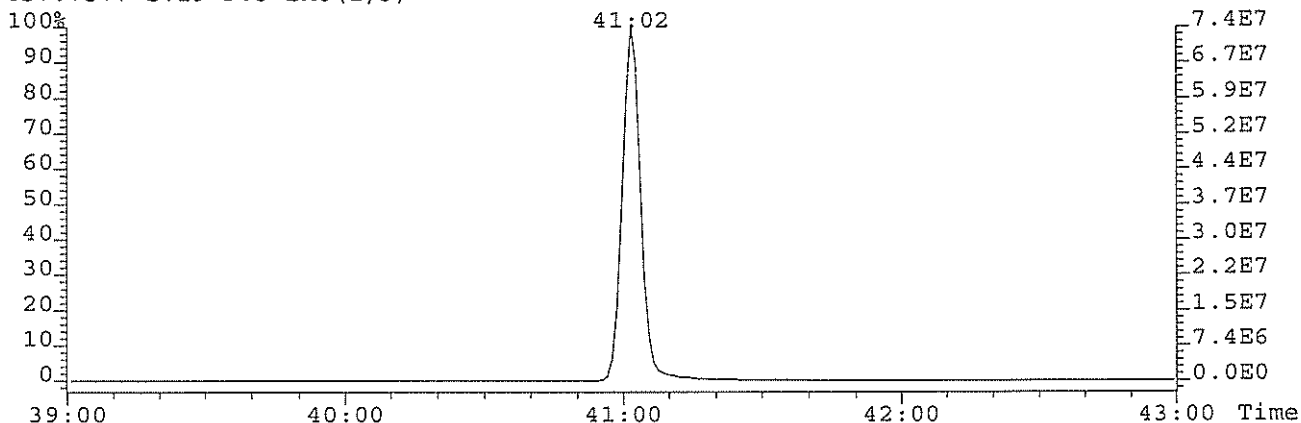
File:130713 #1-561 Acq:14-JUL-2013 03:05:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0965 3 Exp:RH-PD22  
441.7428 S:19 F:3 SMO(1,3)



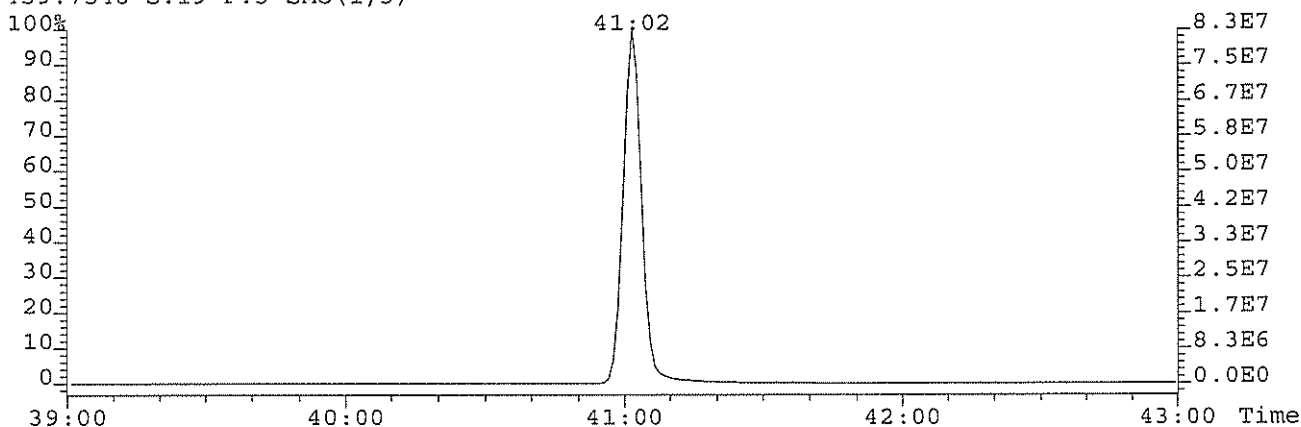
PCDFsクロマトグラム (11)  
(OCDF)



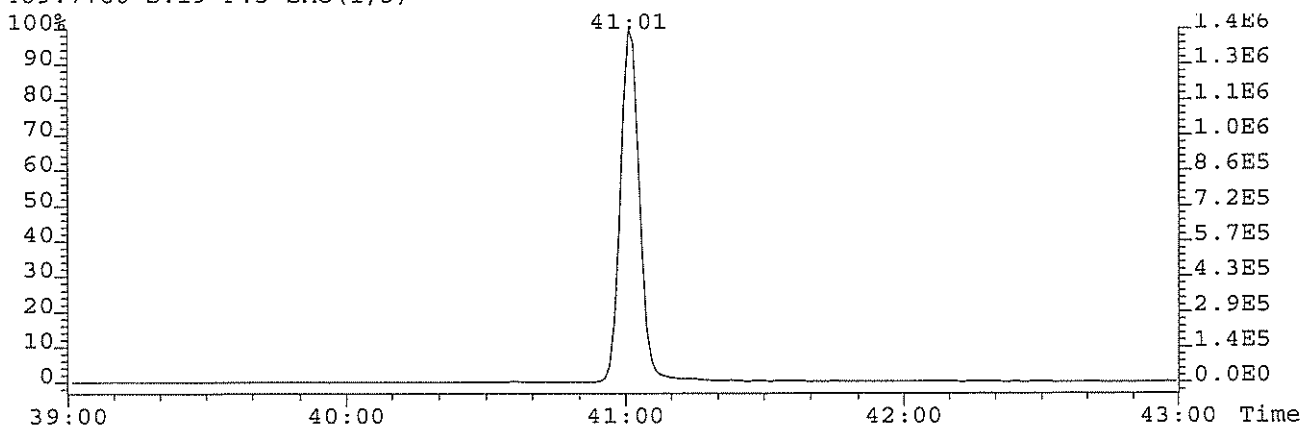
File:130713 #1-561 Acq:14-JUL-2013 03:05:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0965 3 Exp:RH-PD22  
457.7377 S:19 F:3 SMO(1,3)



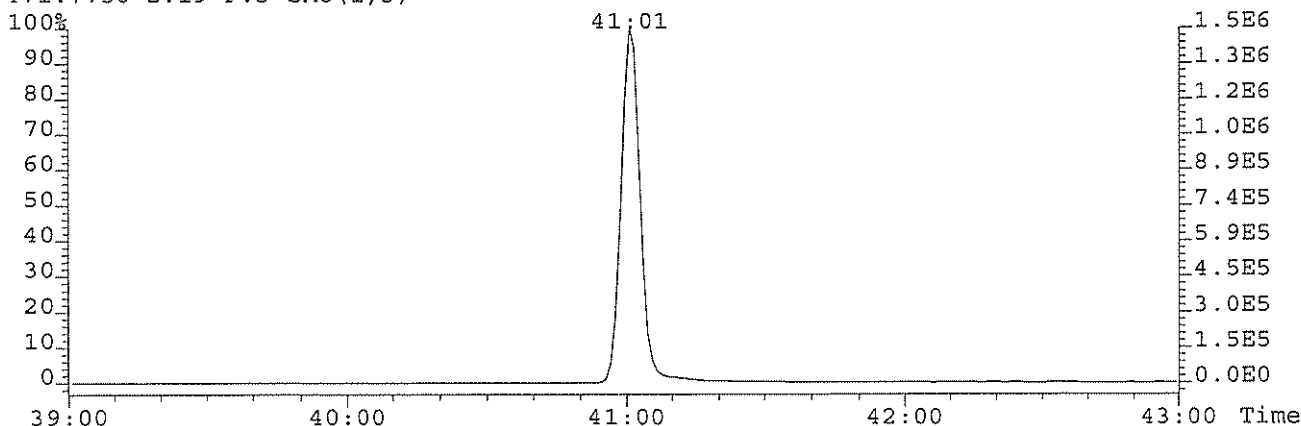
459.7348 S:19 F:3 SMO(1,3)



469.7780 S:19 F:3 SMO(1,3)

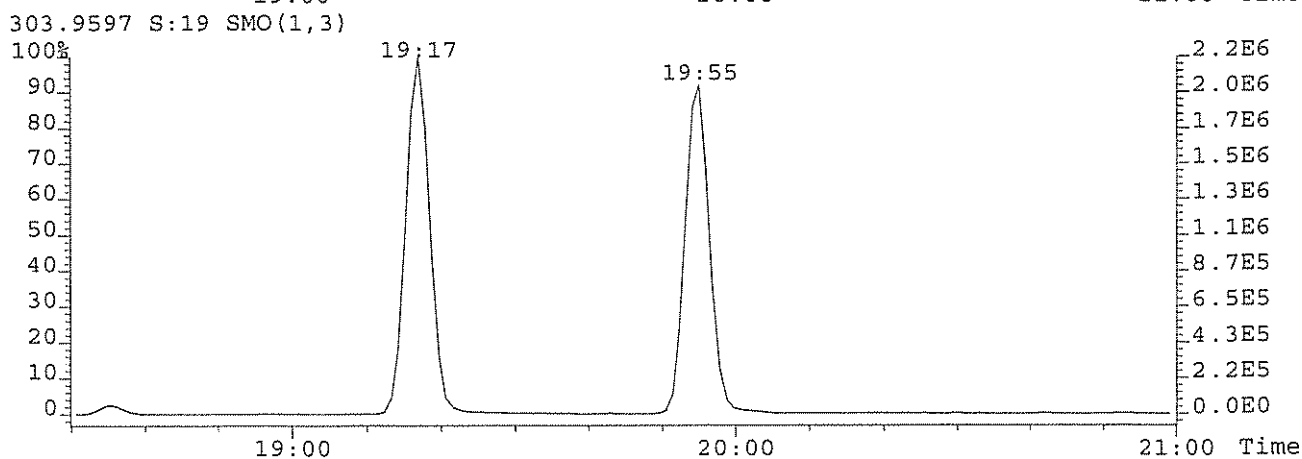
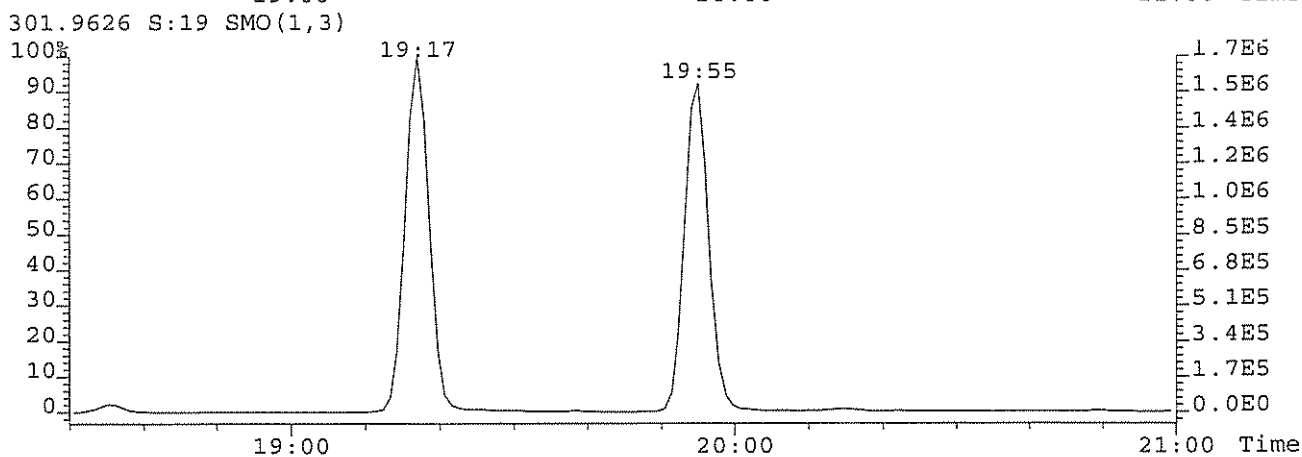
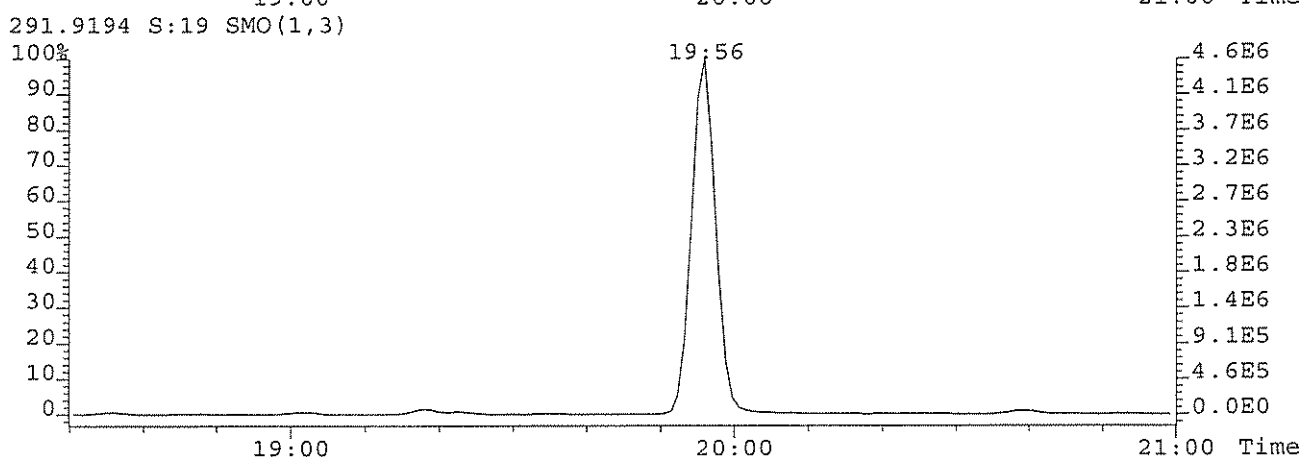
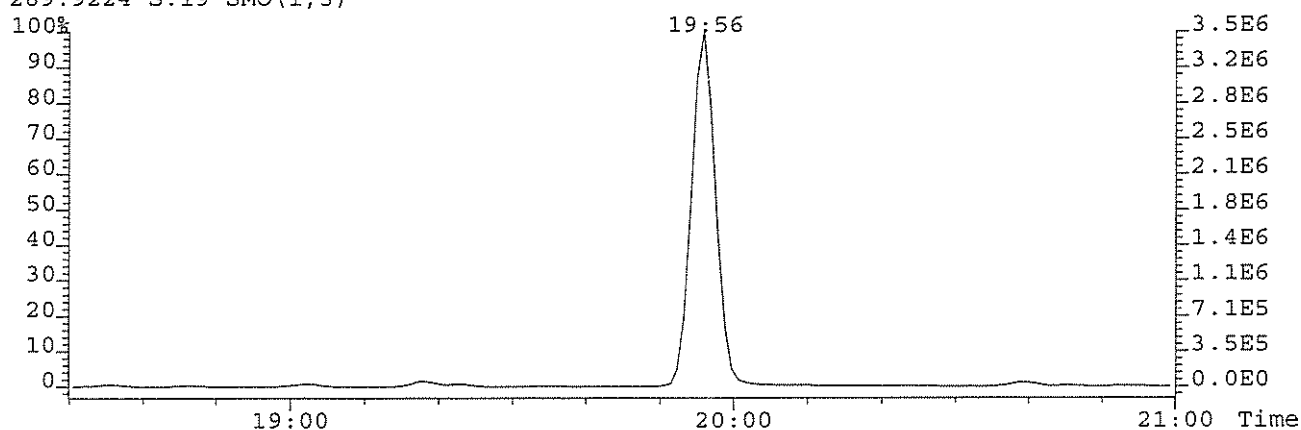


471.7750 S:19 F:3 SMO(1,3)



PCDDsクロマトグラム (12)  
(OCDD)

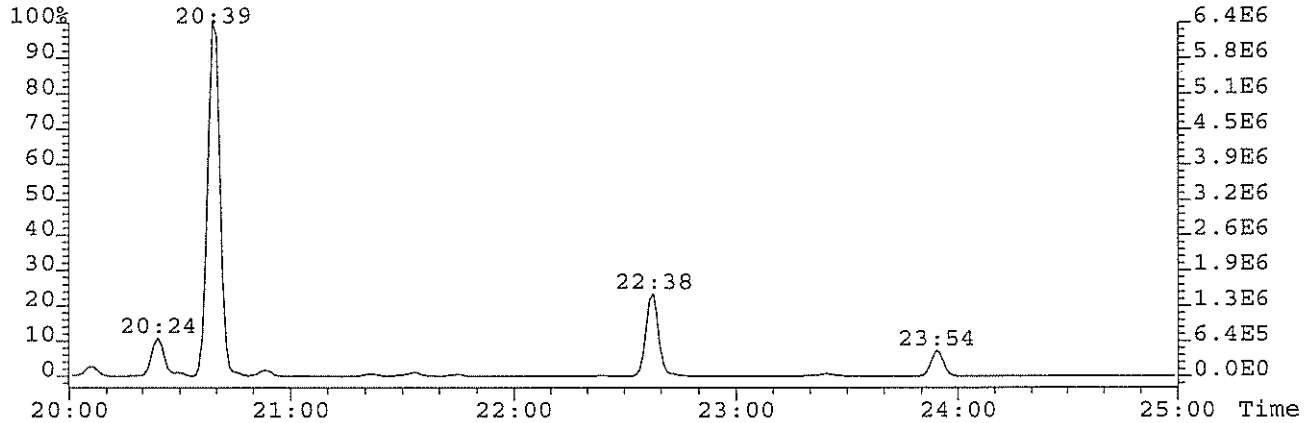
File:130713 #1-1430 Acq:14-JUL-2013 03:05:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0965 3 Exp:RH-PD22  
289.9224 S:19 SMO(1,3)



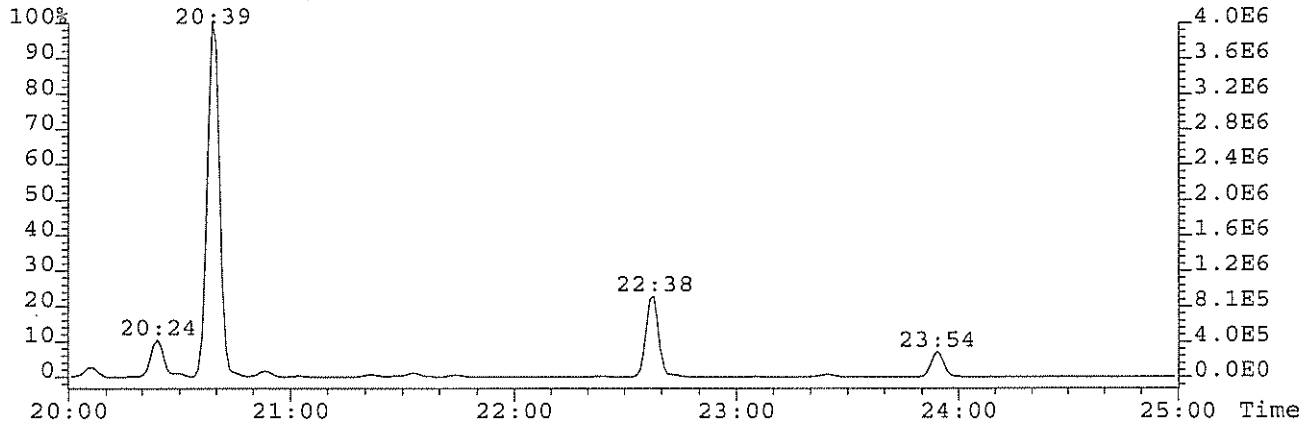
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130713 #1-1430 Acq:14-JUL-2013 03:05:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0965 3 Exp:RH-PD22

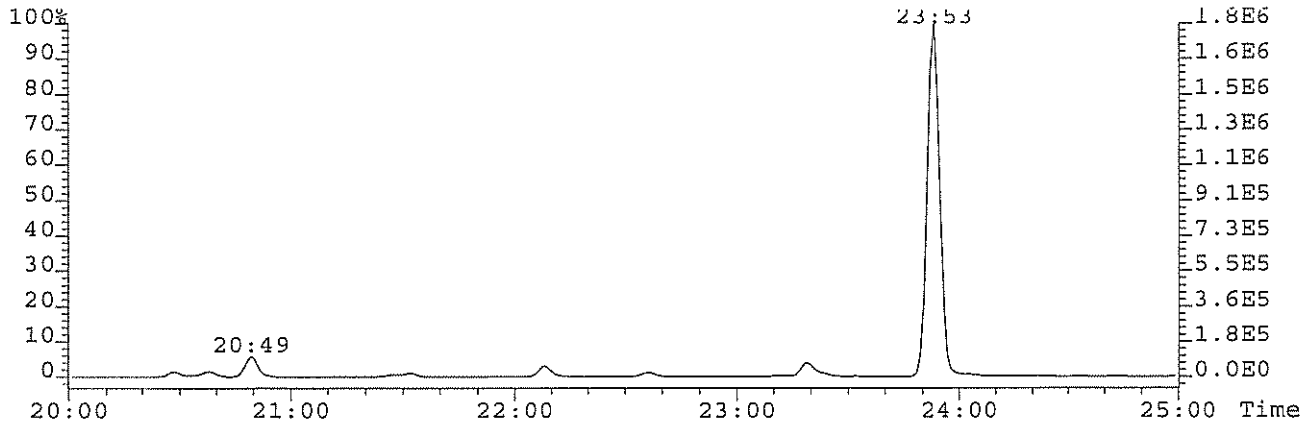
325.8804 S:19 SMO(1,3)



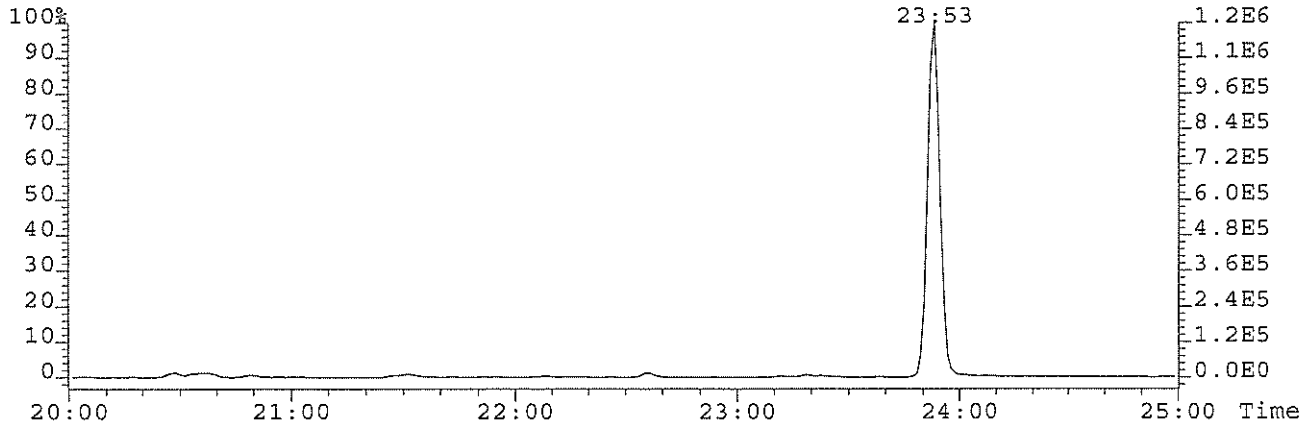
327.8775 S:19 SMO(1,3)



337.9207 S:19 SMO(1,3)



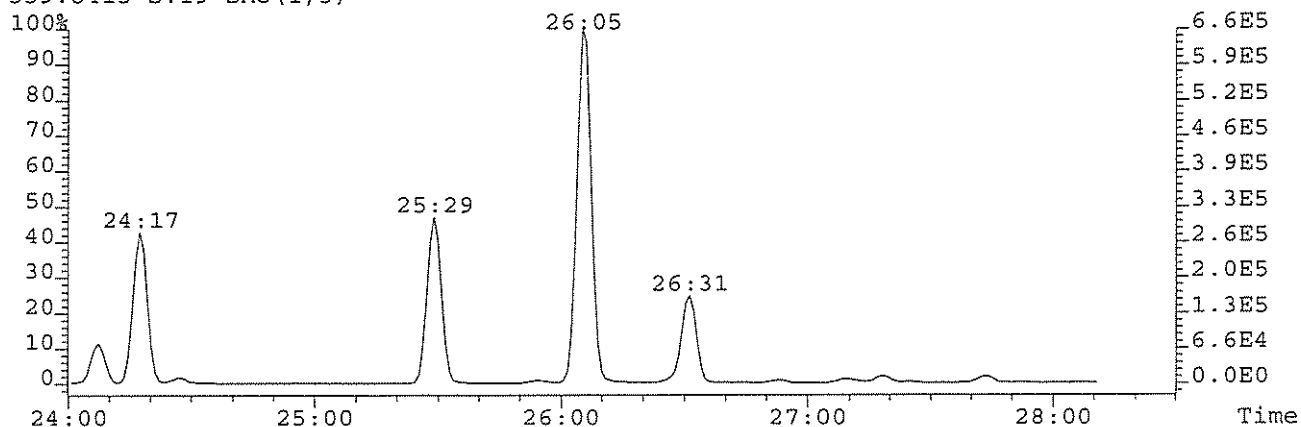
339.9178 S:19 SMO(1,3)



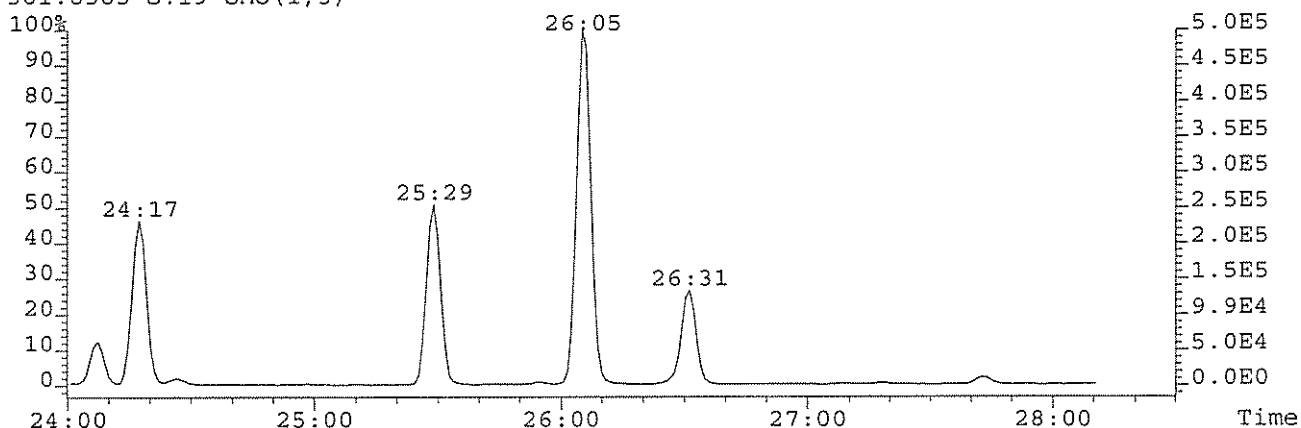
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130713 #1-1430 Acq:14-JUL-2013 03:05:48 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(5-8,nP) Text:XE13 0965 3 Exp:RH-PD22

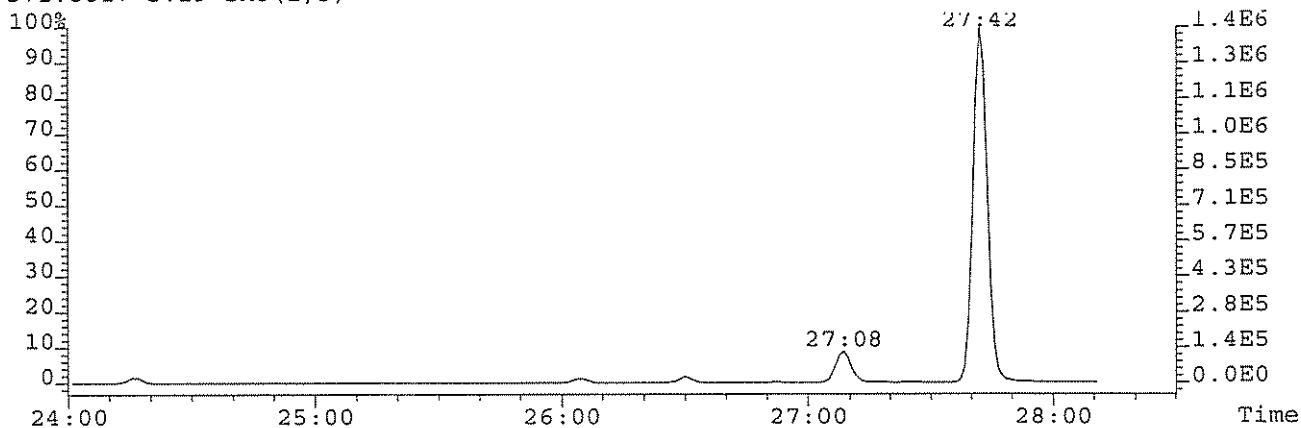
359.8415 S:19 SMO(1,3)



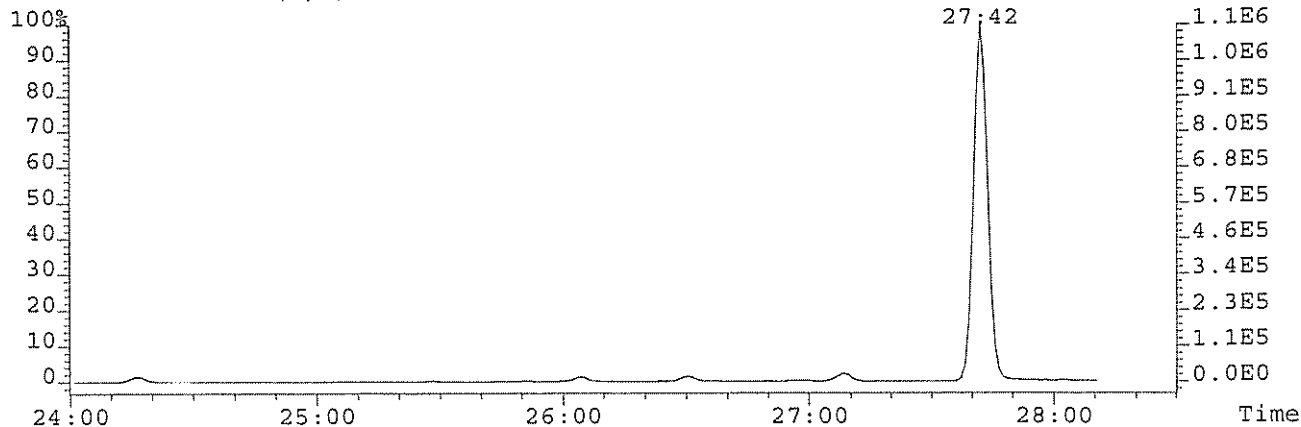
361.8385 S:19 SMO(1,3)



371.8817 S:19 SMO(1,3)

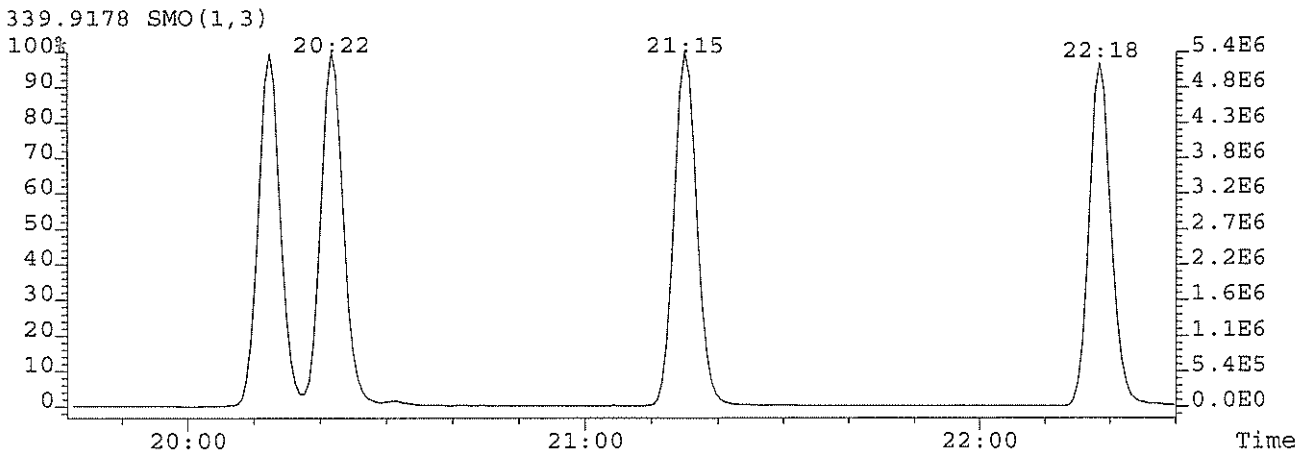
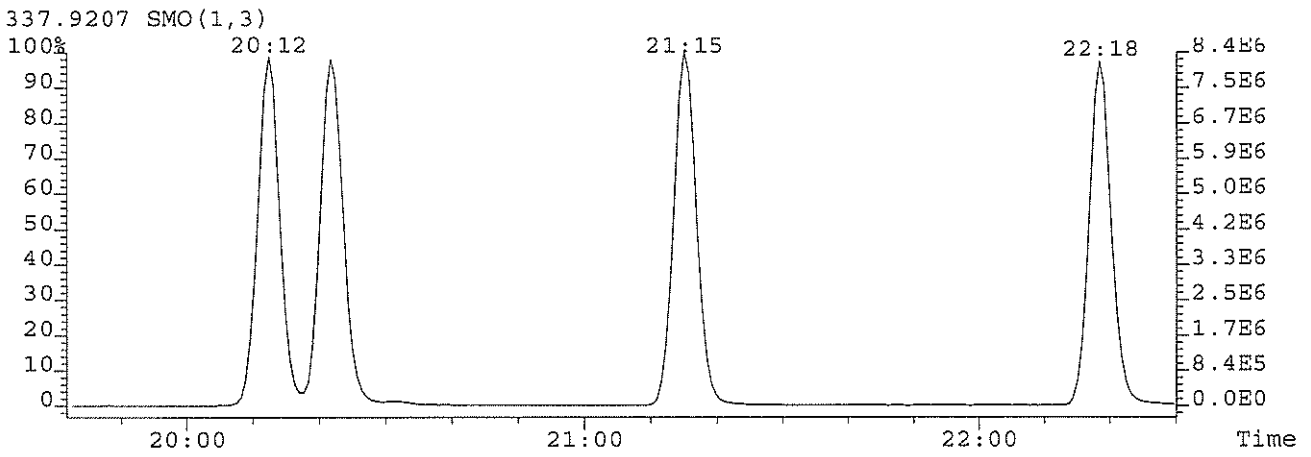
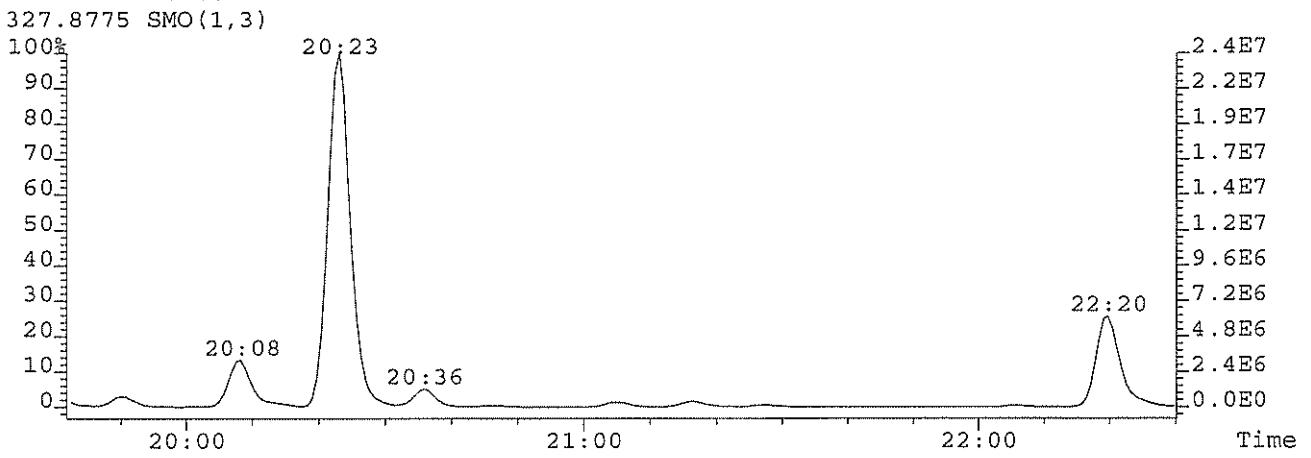
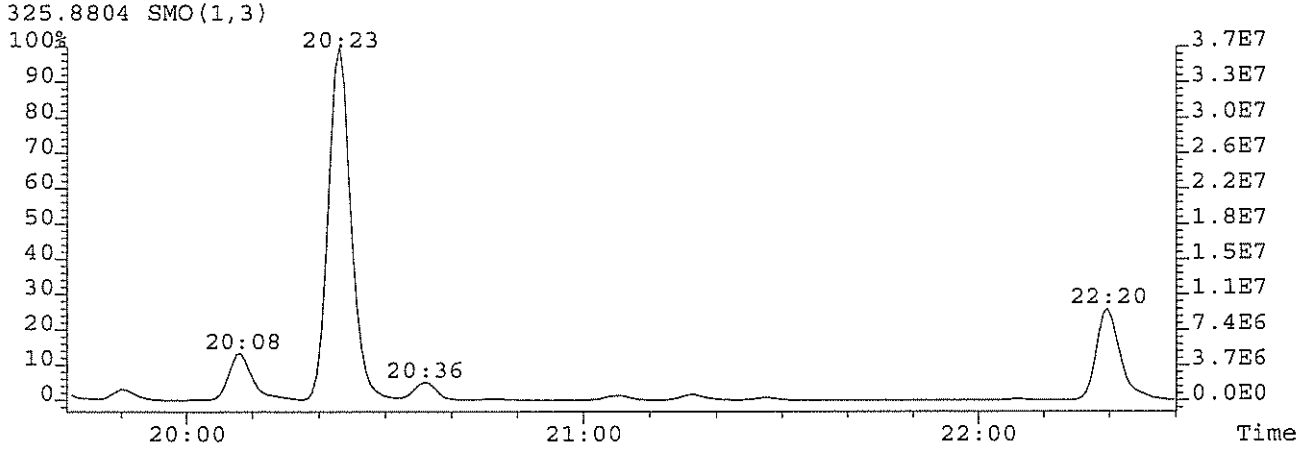


373.8788 S:19 SMO(1,3)



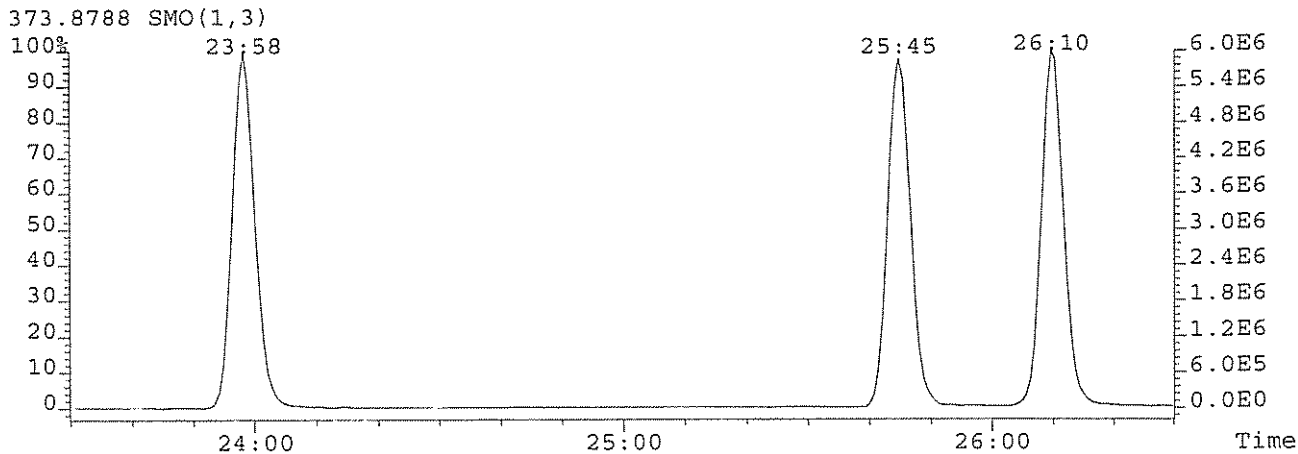
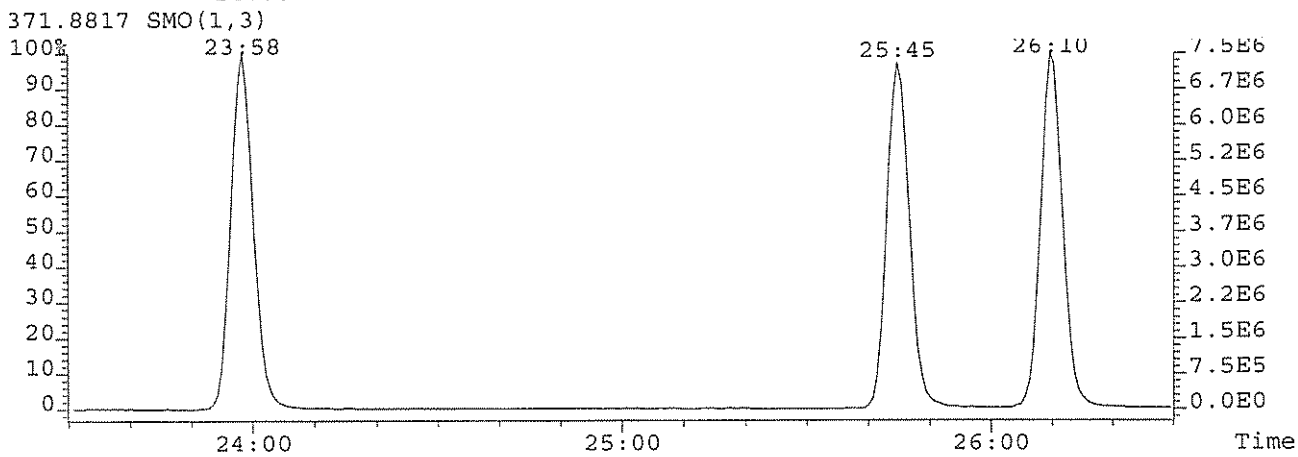
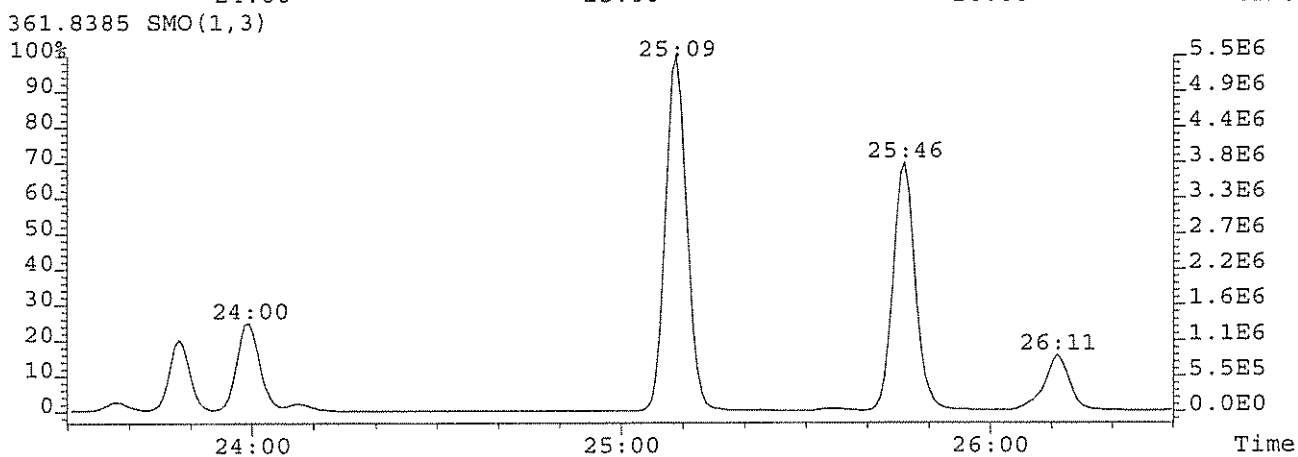
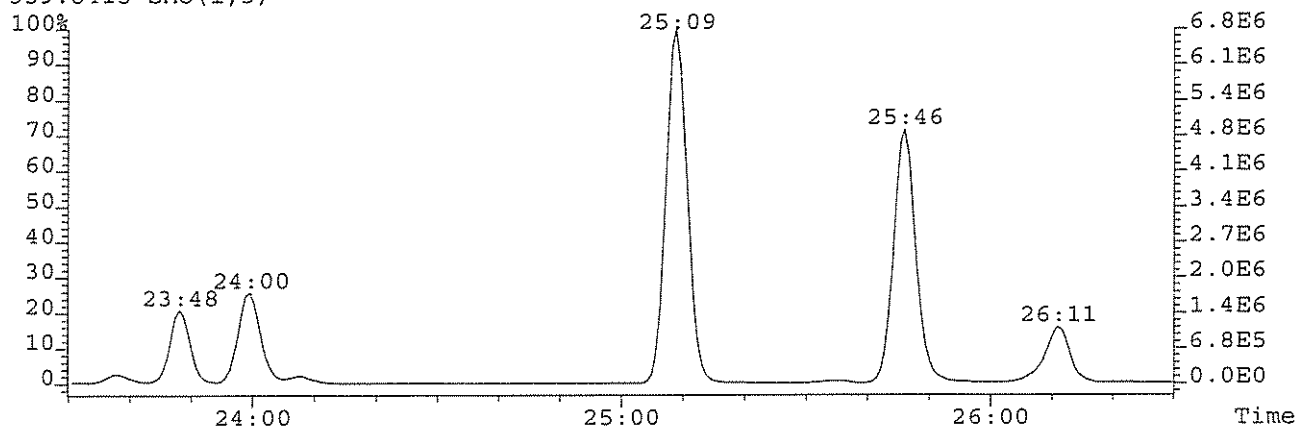
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130717-3 #1-2898 Acq:18-JUL-2013 11:14:47 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(mP) Text:XE13 0965 2 Exp:RH-MP11



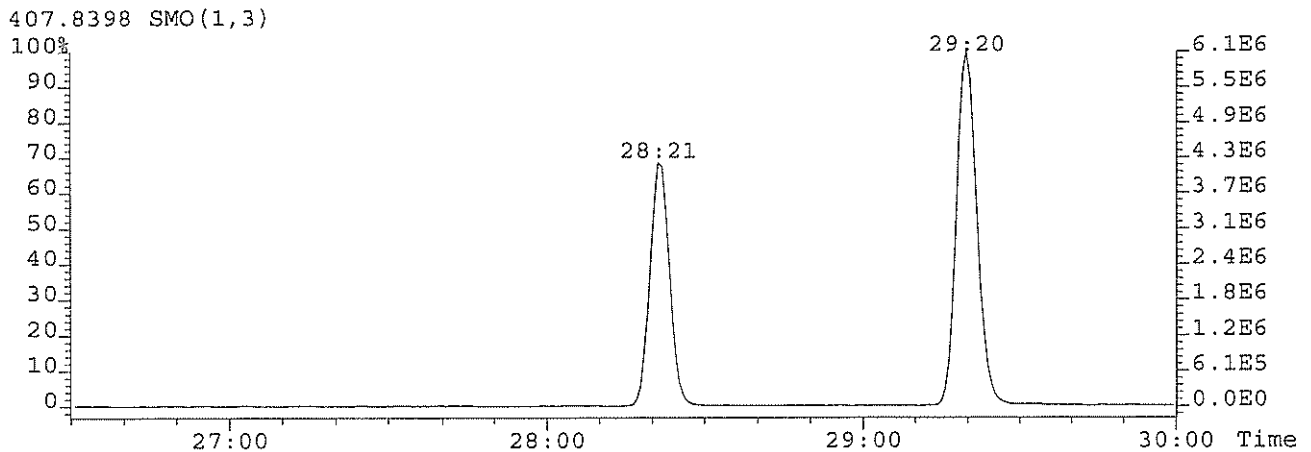
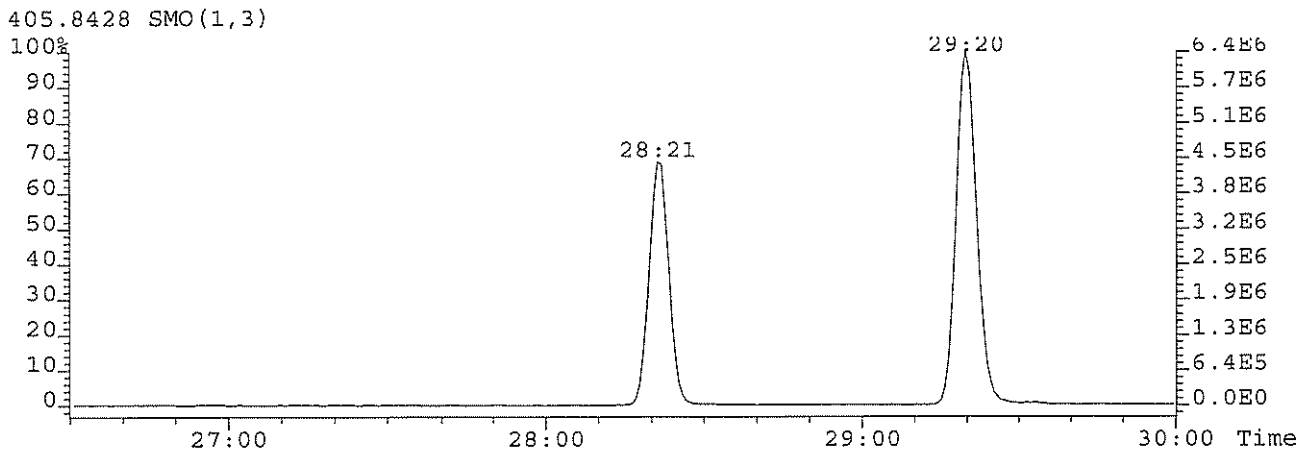
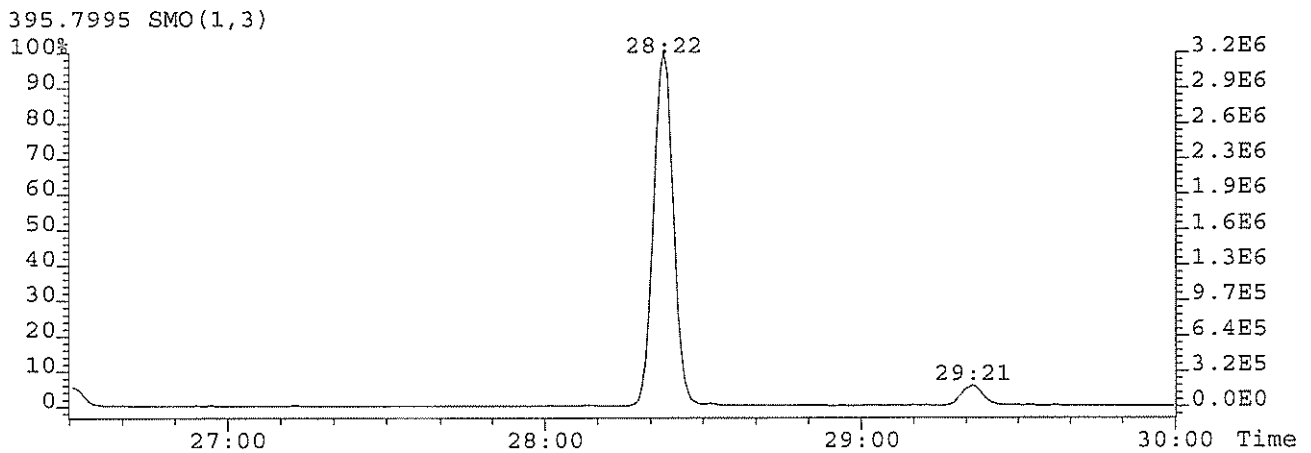
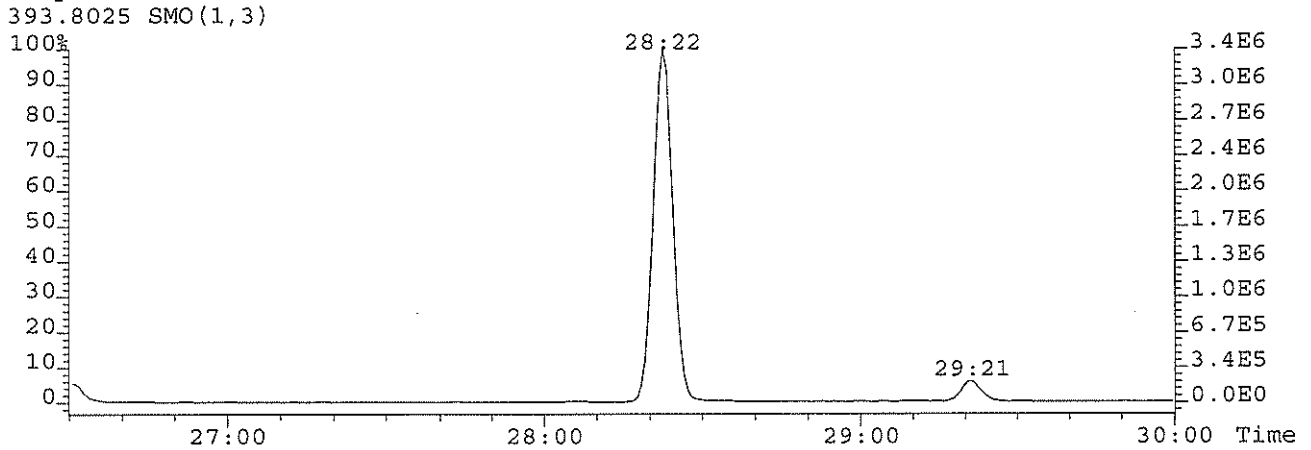
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130717-3 #1-2898 Acq:18-JUL-2013 11:14:47 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(mP) Text:XE13 0965 2 Exp:RH-MP11  
359.8415 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130717-3 #1-2898 Acq:18-JUL-2013 11:14:47 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#1 File Text:RH-12ms(mP) Text:XE13 0965 2 Exp:RH-MP11



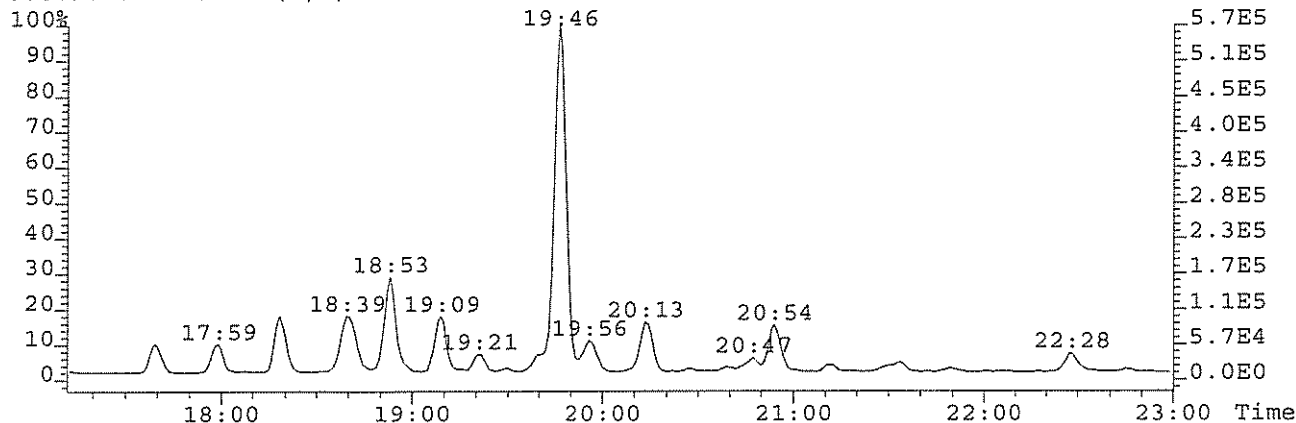
DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

試料管理番号	XE 130966
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.20

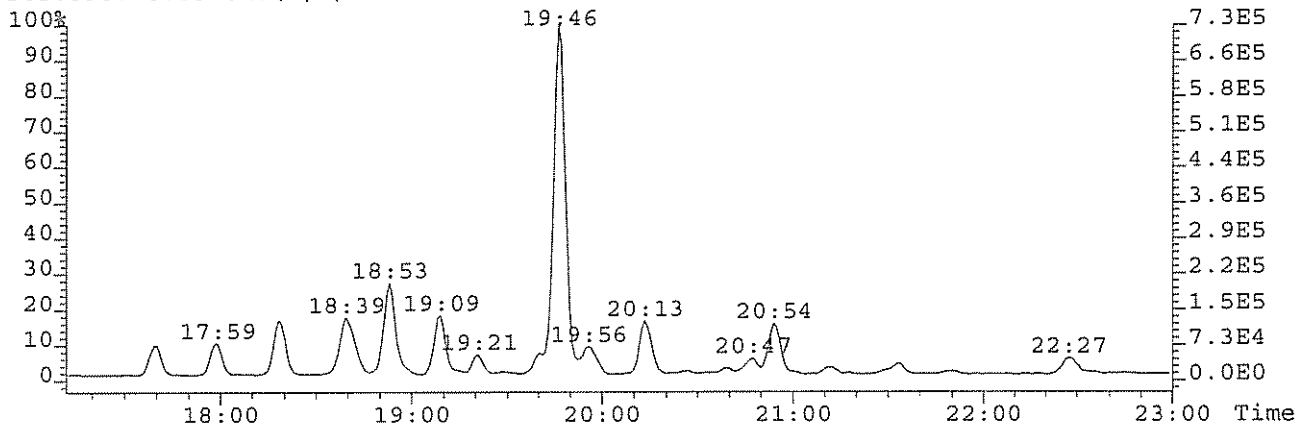


File:130712-2 #1-1578 Acq:13-JUL-2013 09:30:43 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#23 File Text:BPX-DXN(4-6DXN) Text:XE13 0966 Exp:BPX04

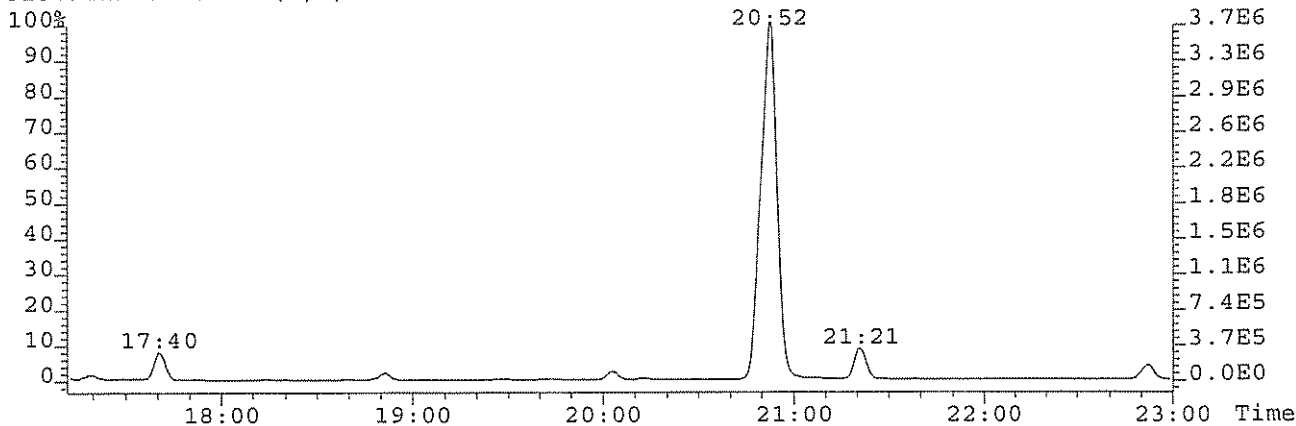
303.9016 S:23 SMO(1,3)



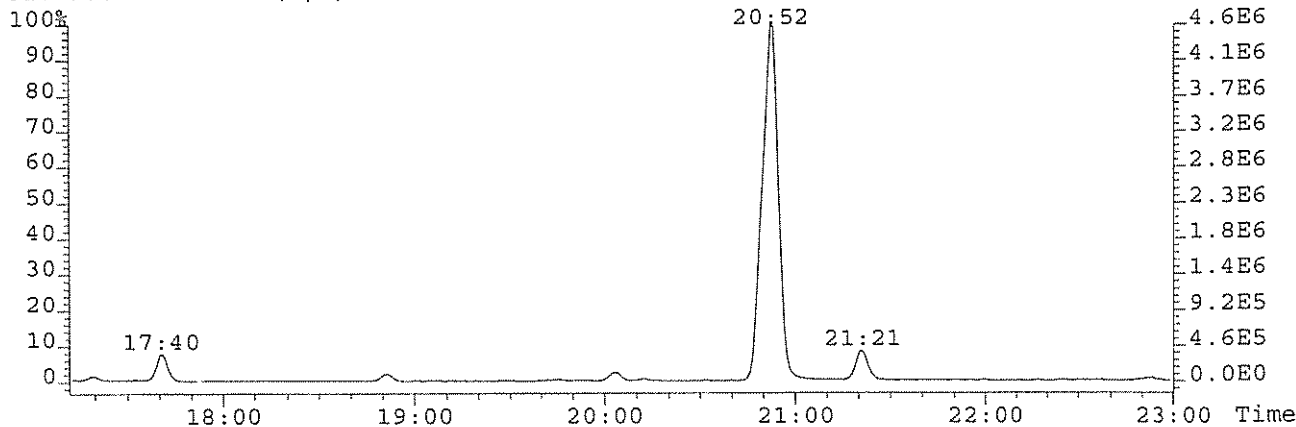
305.8987 S:23 SMO(1,3)



315.9419 S:23 SMO(1,3)

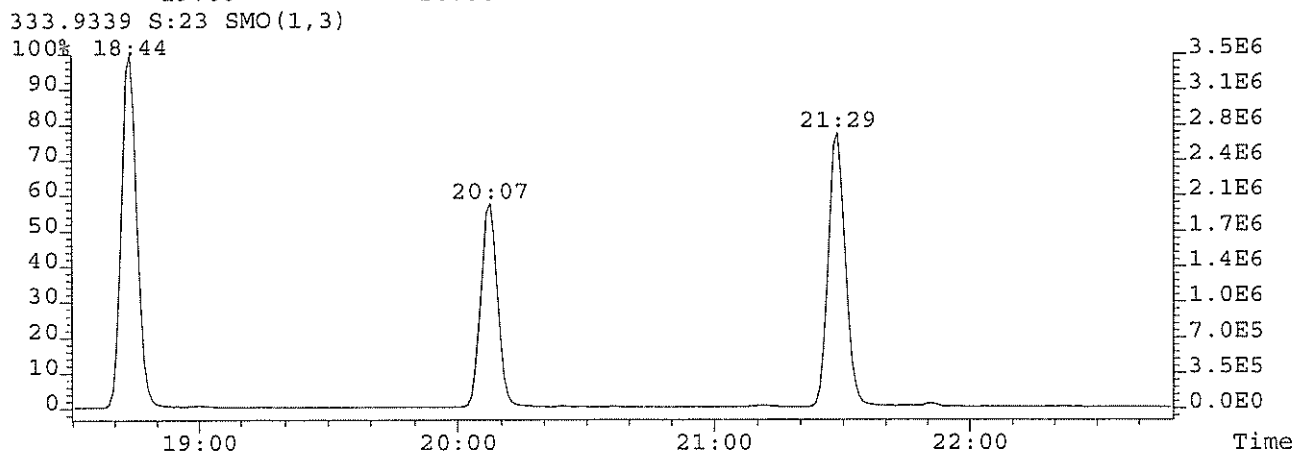
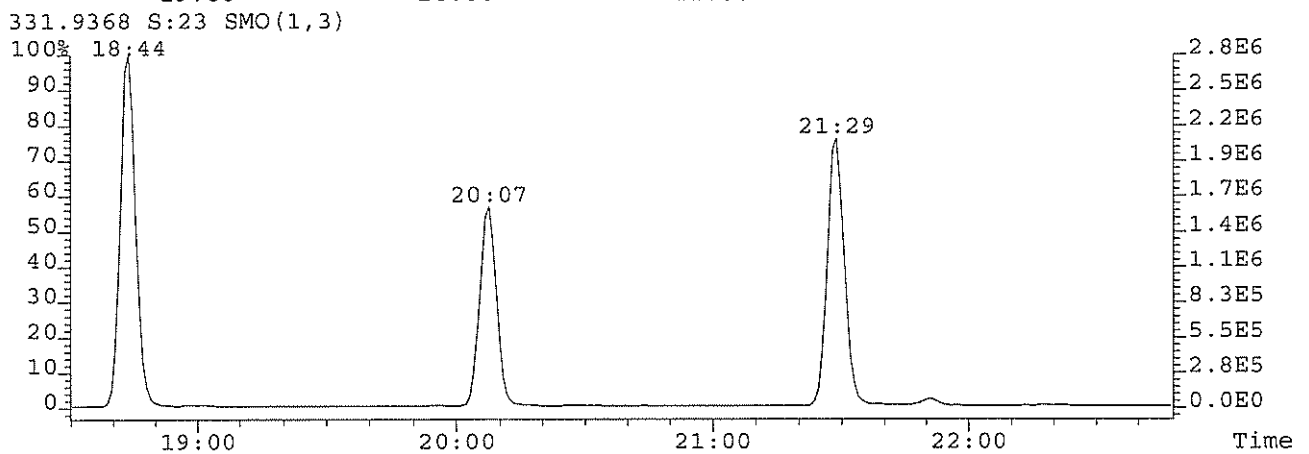
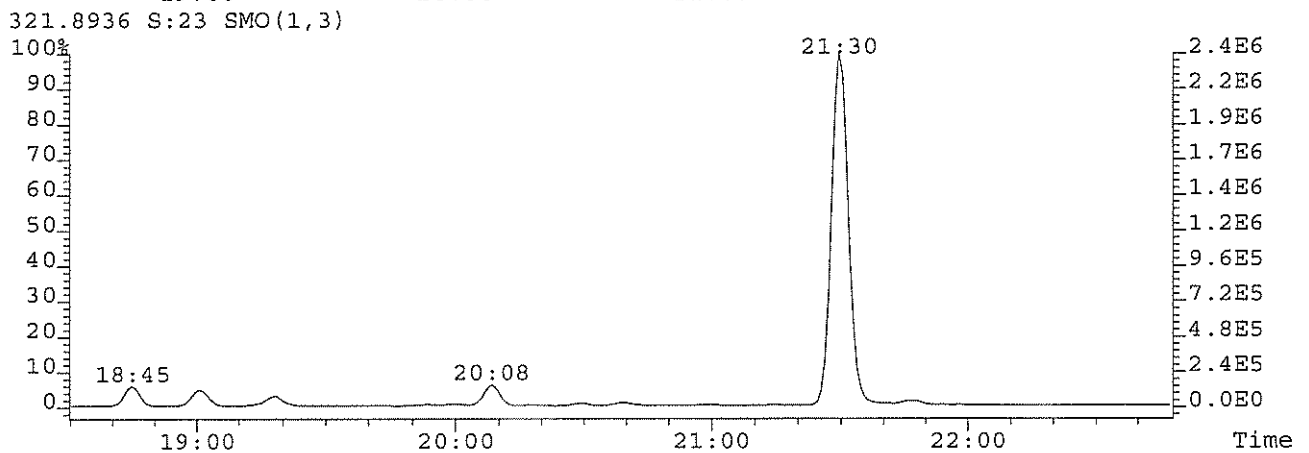
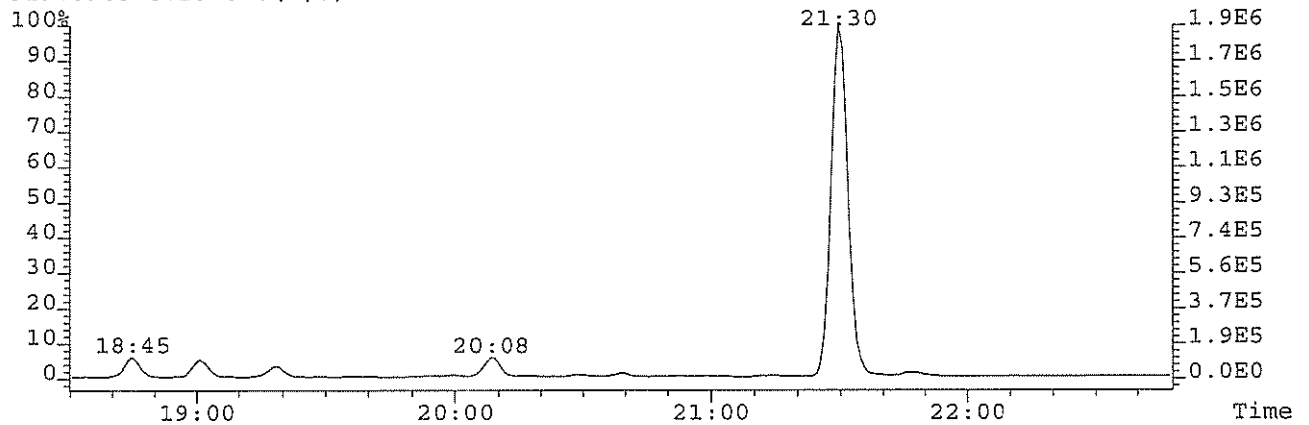


317.9389 S:23 SMO(1,3)



PCDFsクロマトグラム (1)  
(TeCDFs)

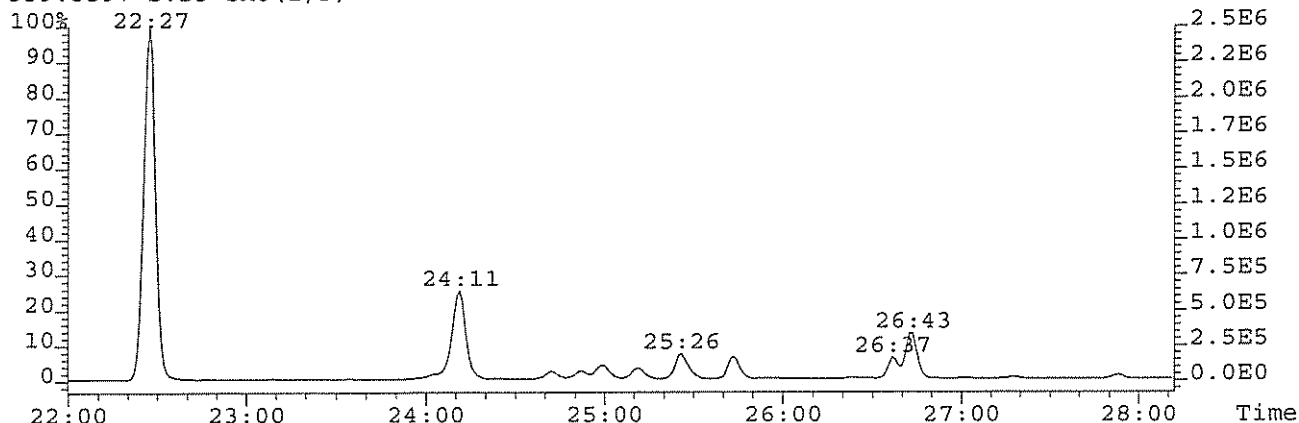
File:130712-2 #1-1578 Acq:13-JUL-2013 09:30:43 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#23 File Text:BPX-DXN(4-6DXN) Text:XE13 0966 Exp:BPX04  
319.8965 S:23 SMO(1,3)



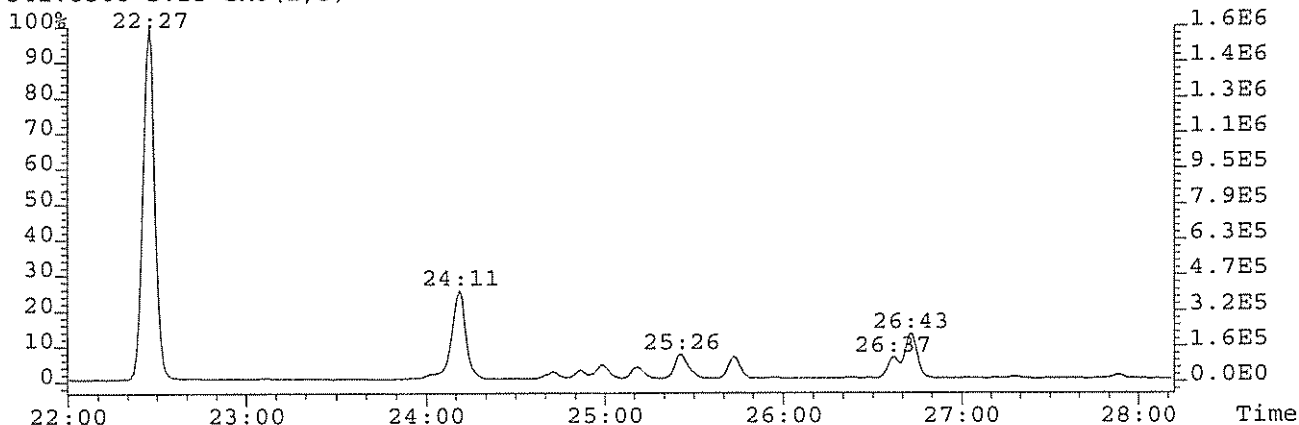
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130712-2 #1-1578 Acq:13-JUL-2013 09:30:43 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#23 File Text:BPX-DXN(4-6DXN) Text:XE13 0966 Exp:BPX04

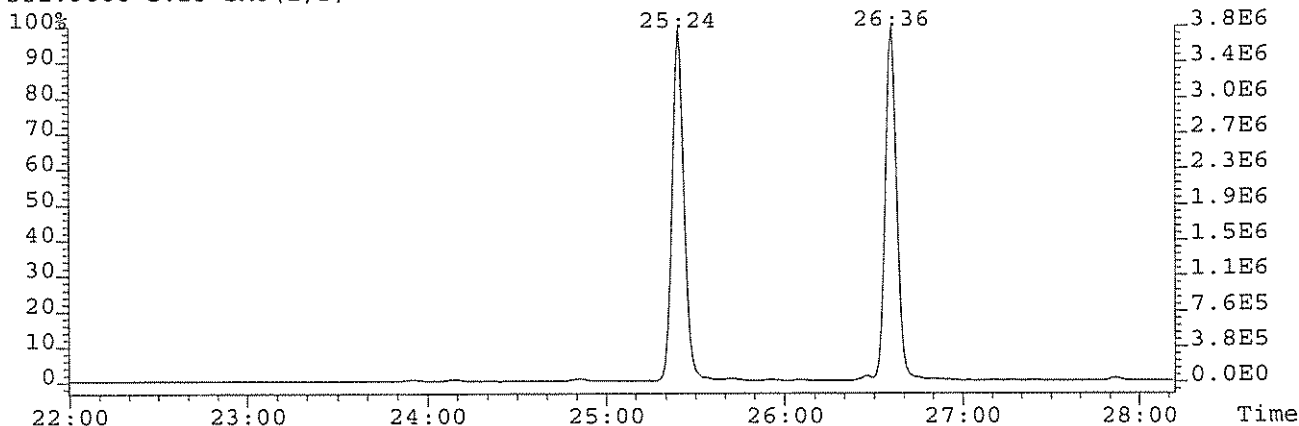
339.8597 S:23 SMO(1,3)



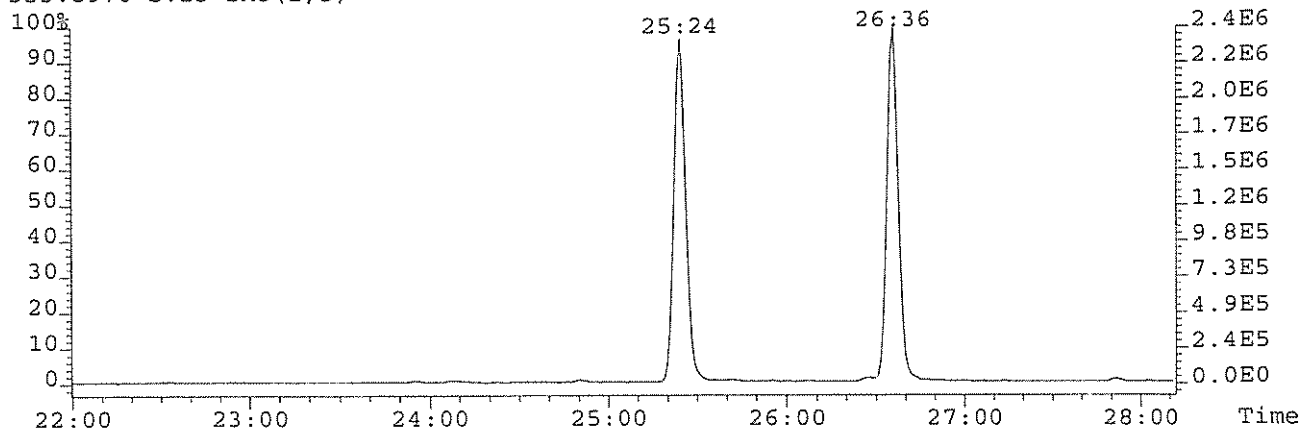
341.8568 S:23 SMO(1,3)



351.9000 S:23 SMO(1,3)

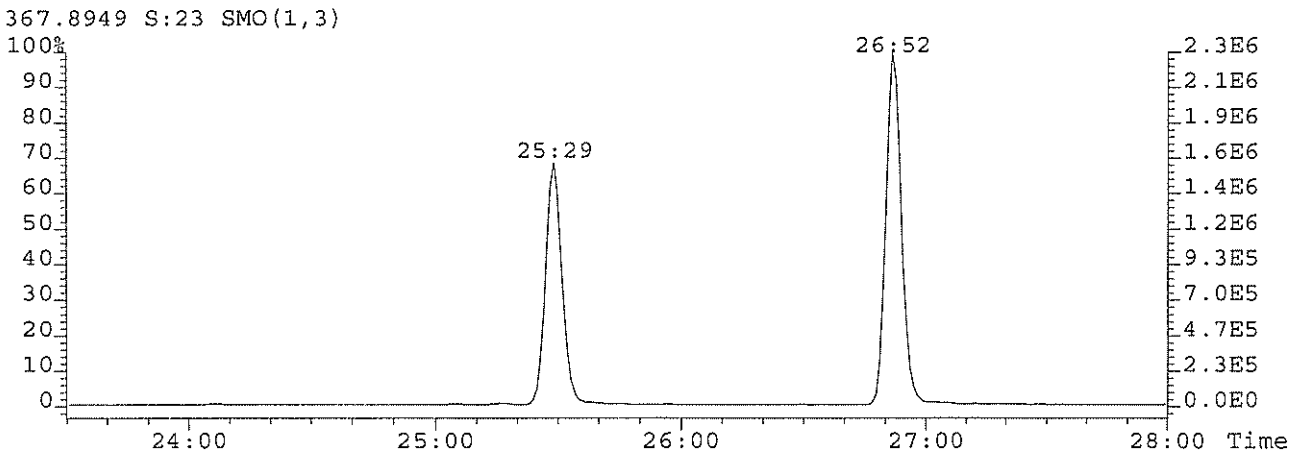
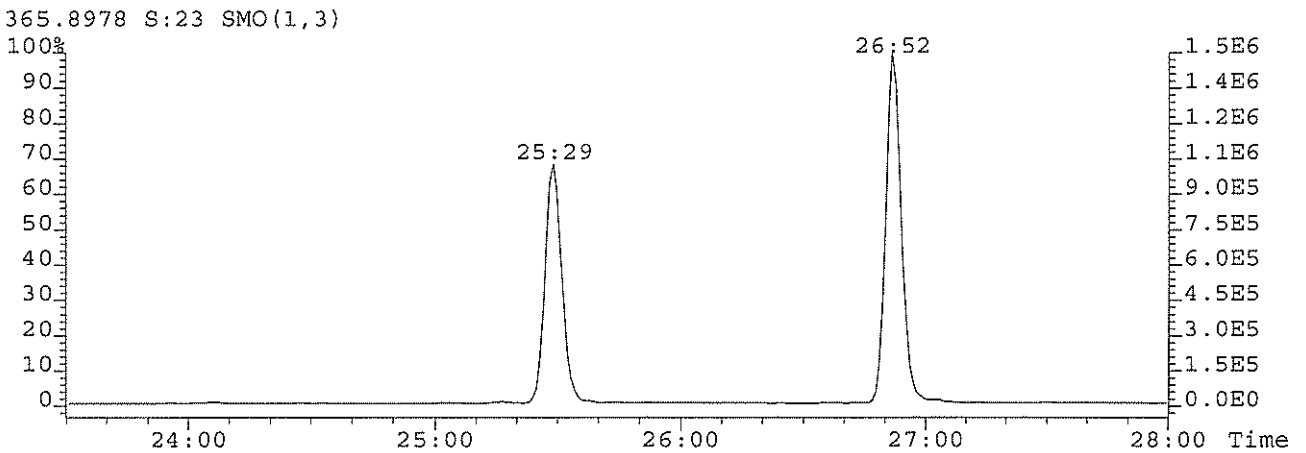
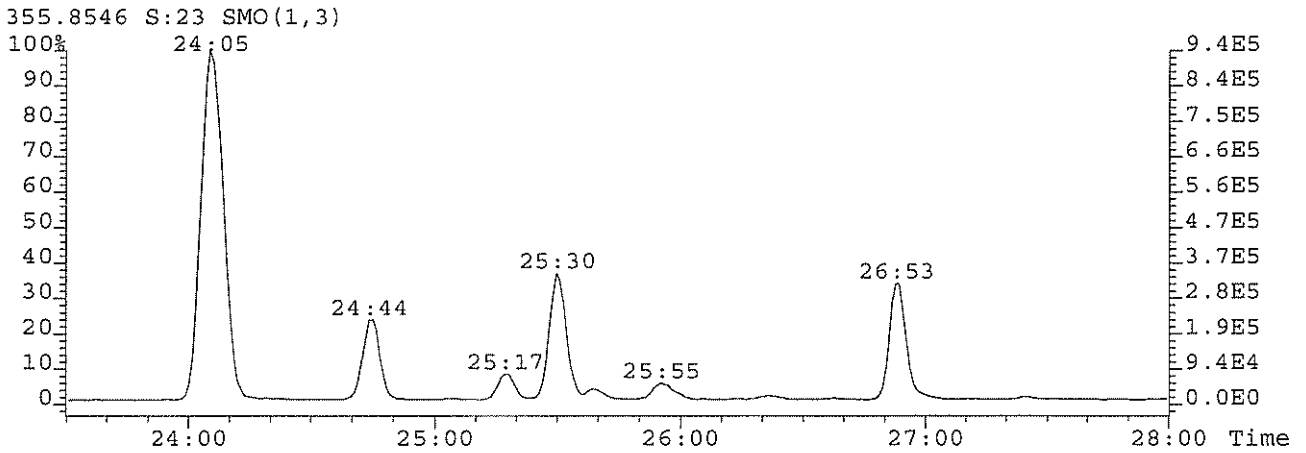
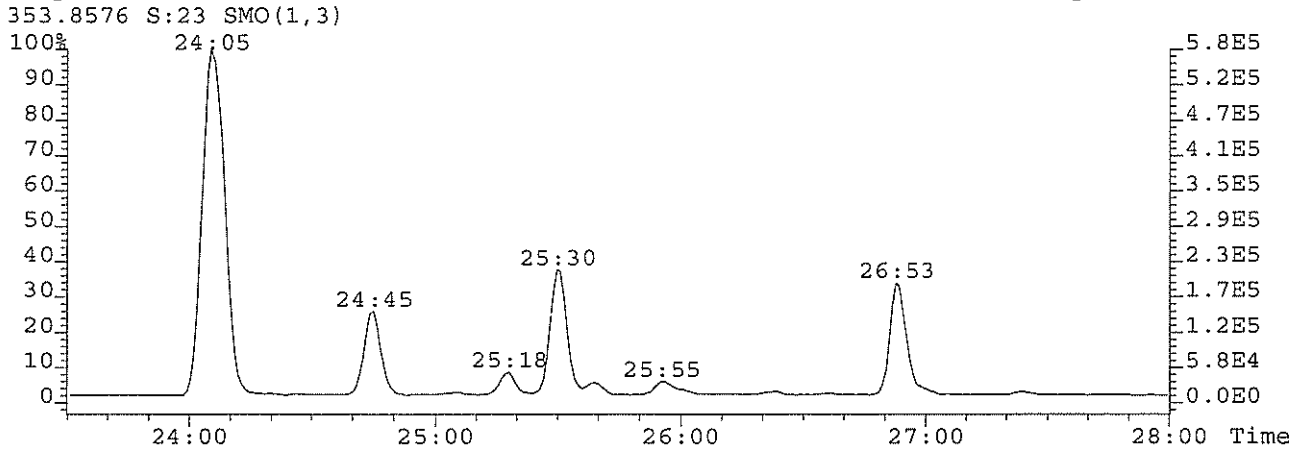


353.8970 S:23 SMO(1,3)



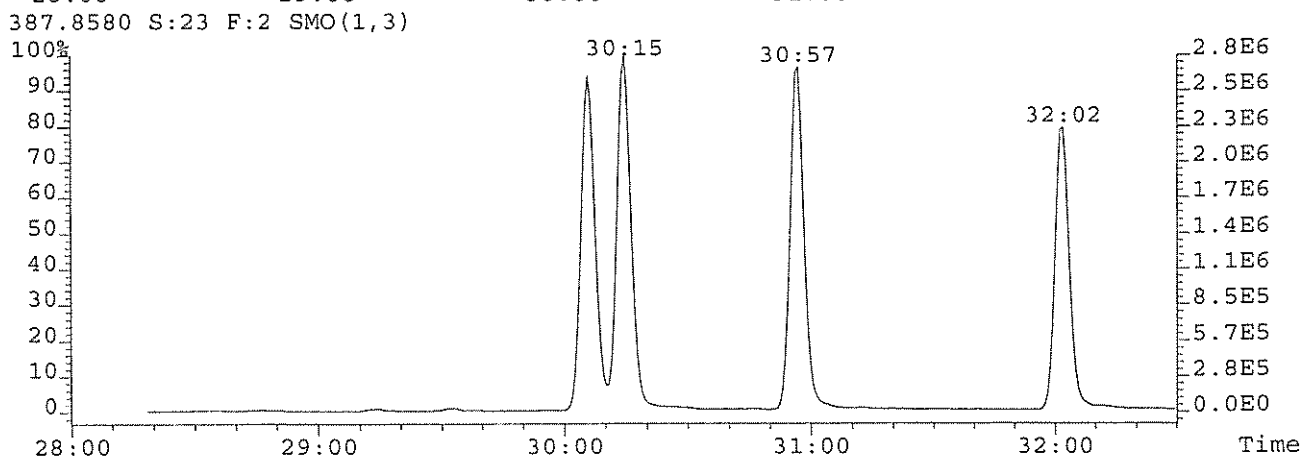
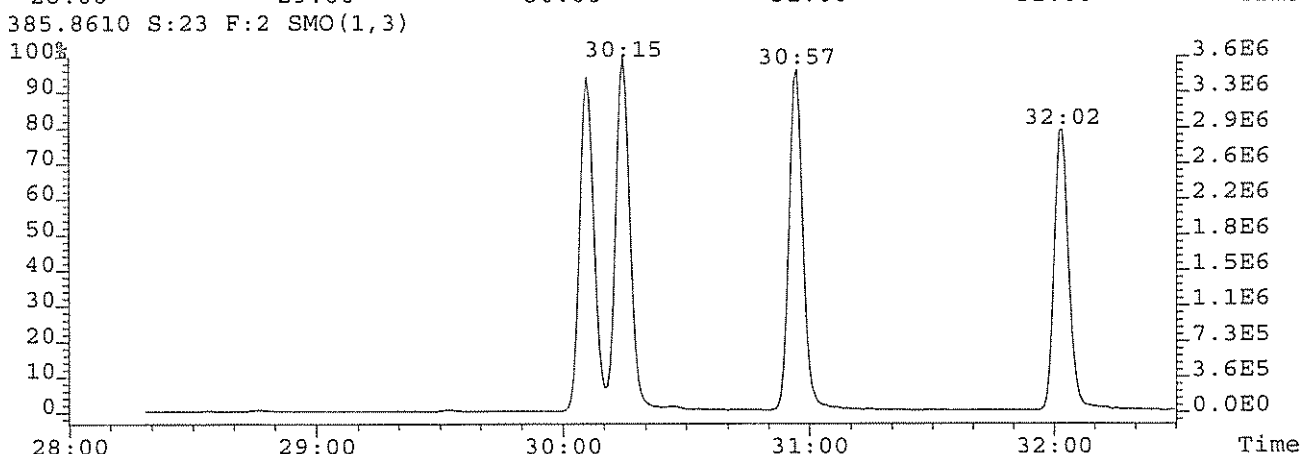
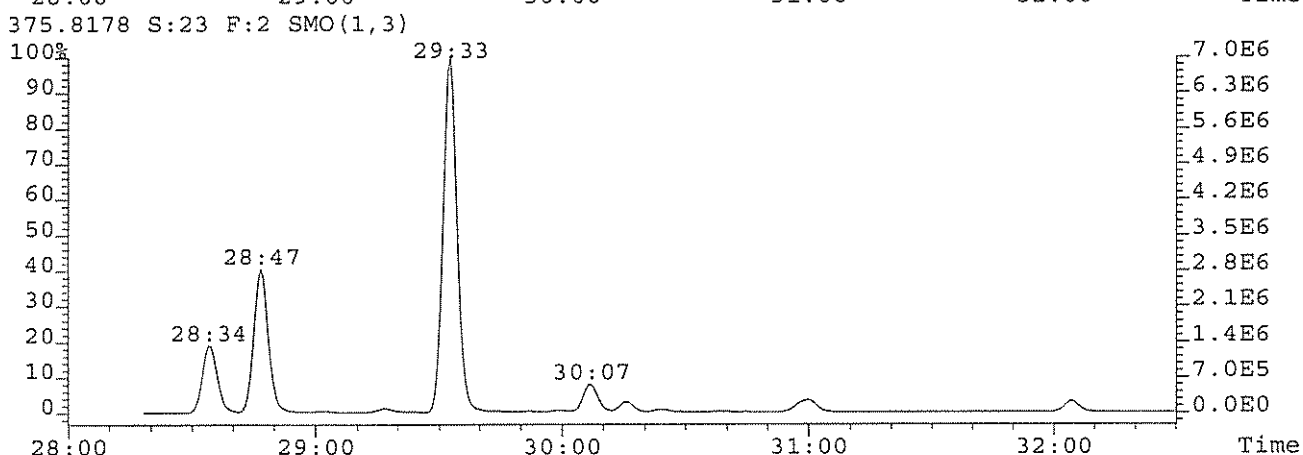
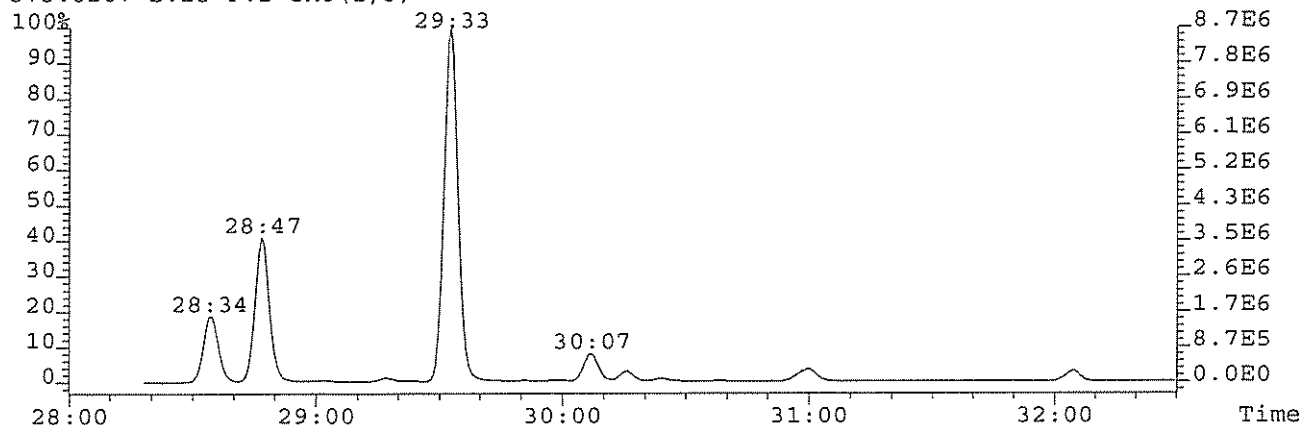
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 09:30:43 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#23 File Text:BPX-DXN(4-6DXN) Text:XE13 0966 Exp:BPX04



PCDDsクロマトグラム (4)  
(PeCDDs)

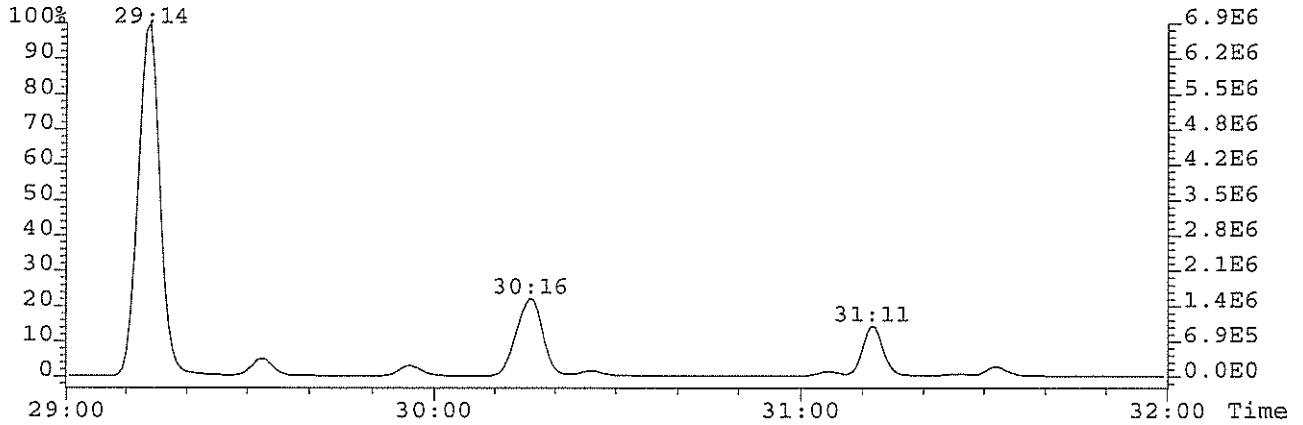
File:130712-2 #1-1116 Acq:13-JUL-2013 09:30:43 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#23 File Text:BPX-DXN(4-6DXN) Text:XE13 0966 Exp:BPX04  
373.8207 S:23 F:2 SMO(1,3)



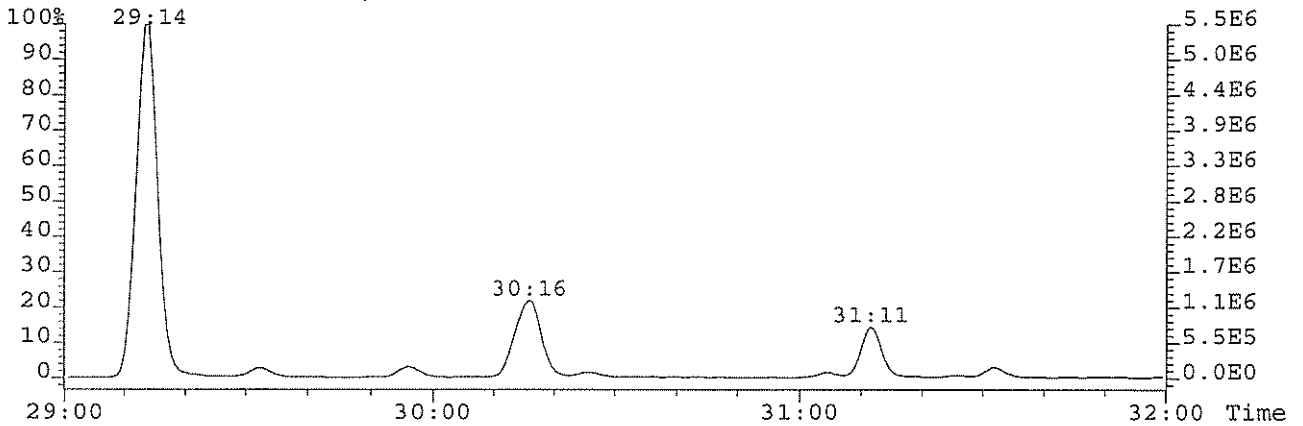
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1116 Acq:13-JUL-2013 09:30:43 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#23 File Text:BPX-DXN(4-6DXN) Text:XE13 0966 Exp:BPX04

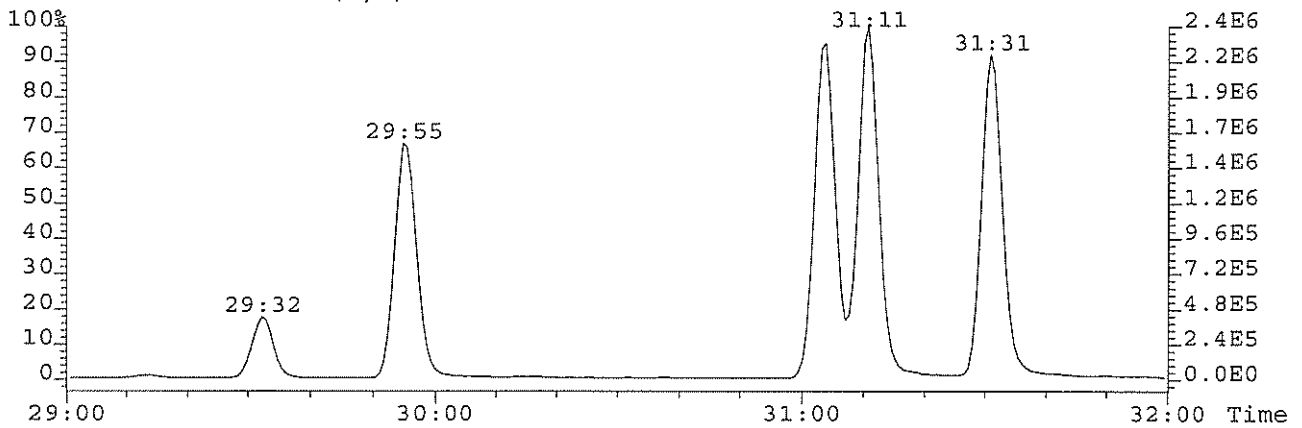
389.8156 S:23 F:2 SMO(1,3)



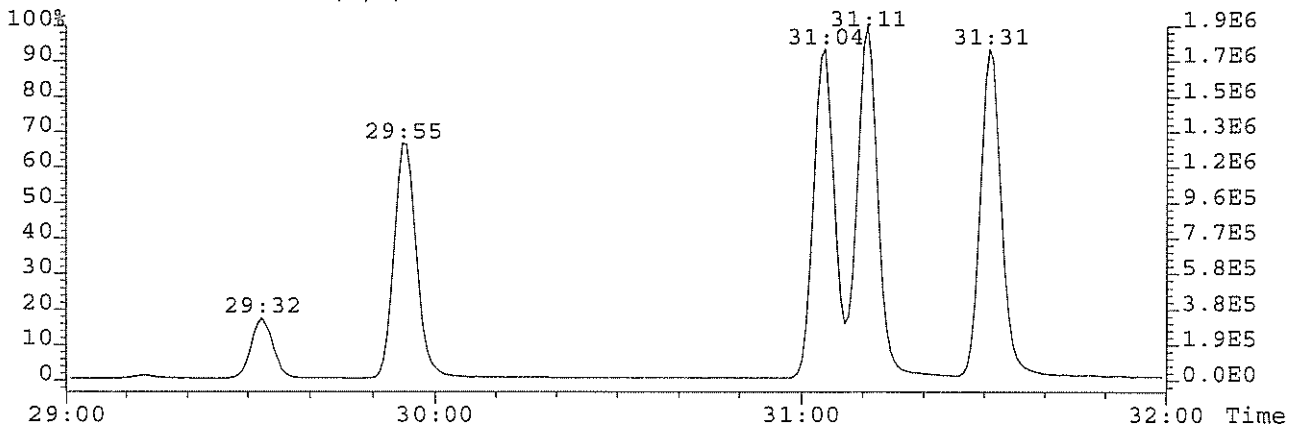
391.8127 S:23 F:2 SMO(1,3)



401.8559 S:23 F:2 SMO(1,3)



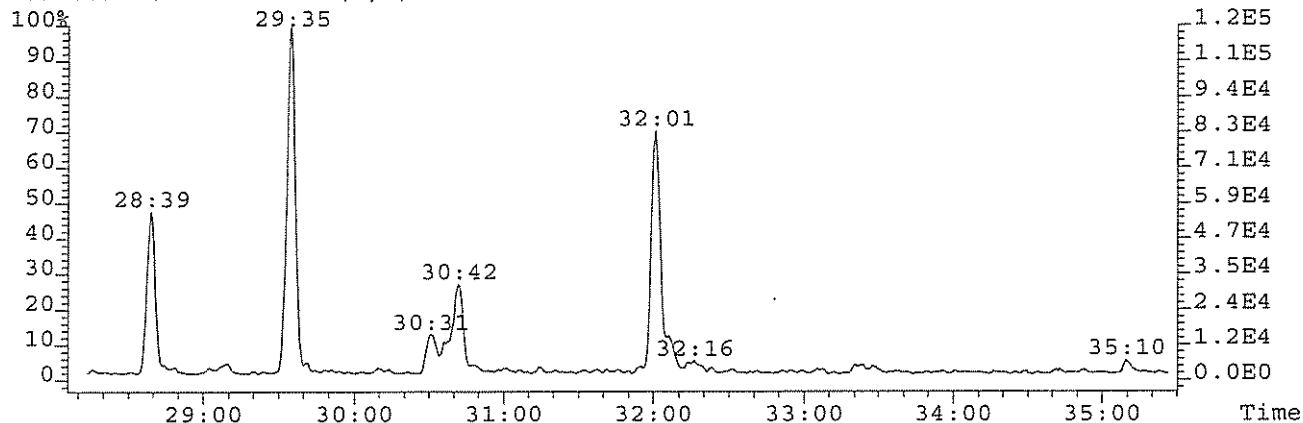
403.8530 S:23 F:2 SMO(1,3)



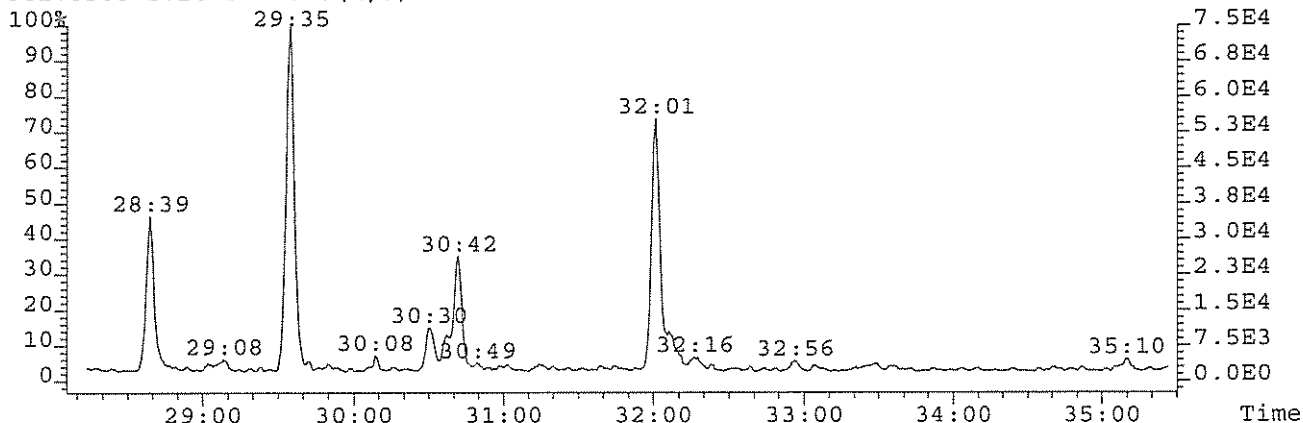
PCDDsクロマトグラム (6)  
(HxCDDs)

File:130713 #1-648 Acq:14-JUL-2013 03:55:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0966 3 Exp:RH-PD22

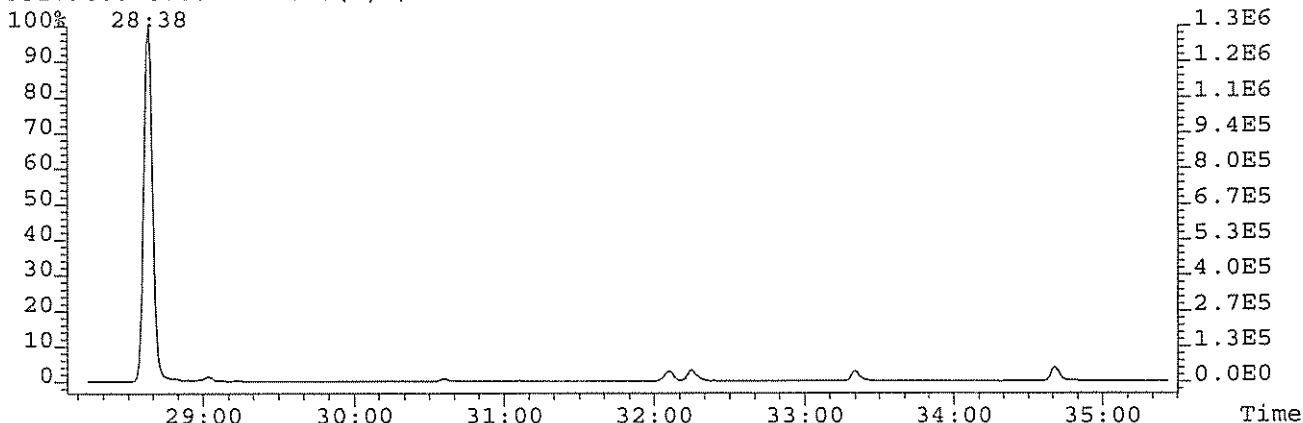
339.8597 S:20 F:2 SMO(1,3)



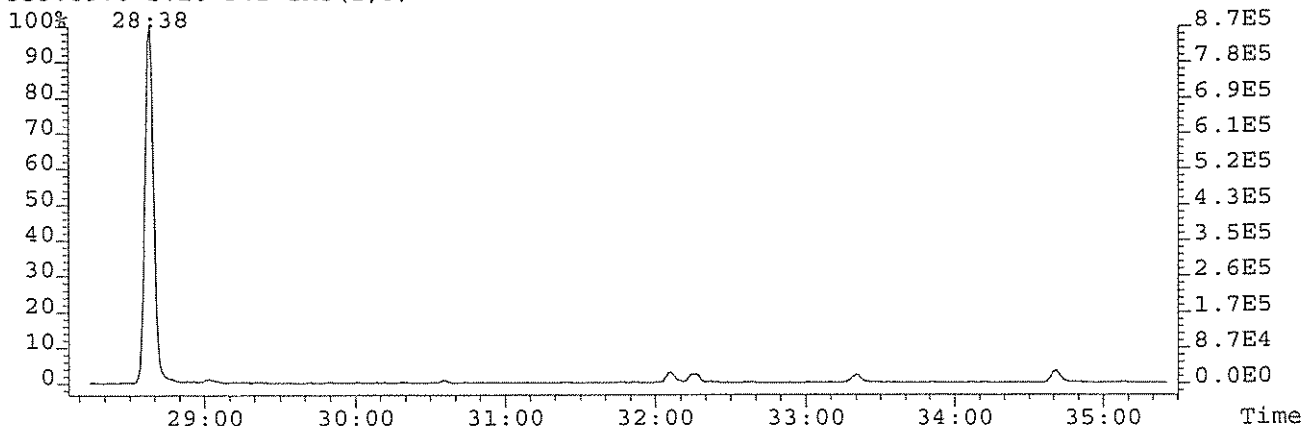
341.8568 S:20 F:2 SMO(1,3)



351.9000 S:20 F:2 SMO(1,3)

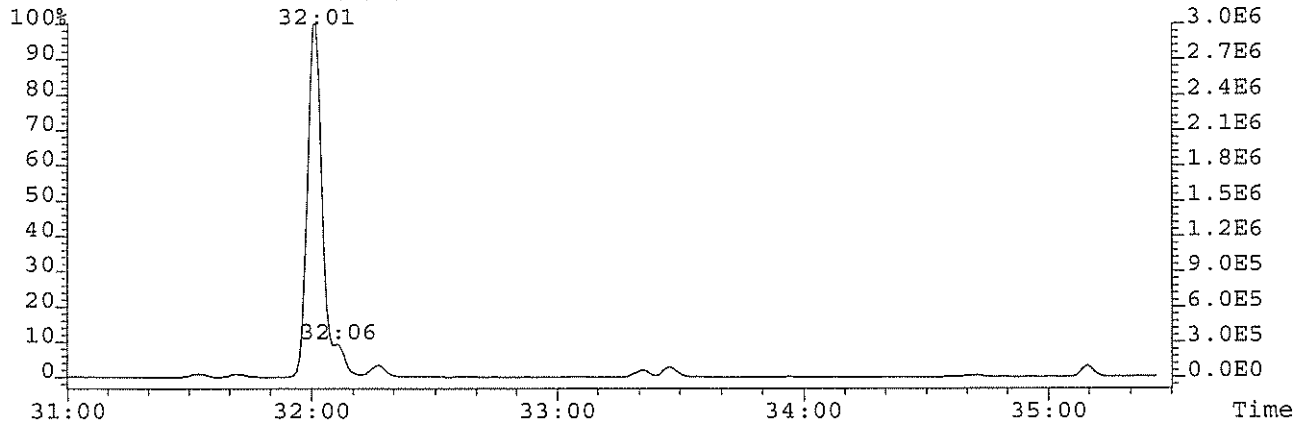


353.8970 S:20 F:2 SMO(1,3)

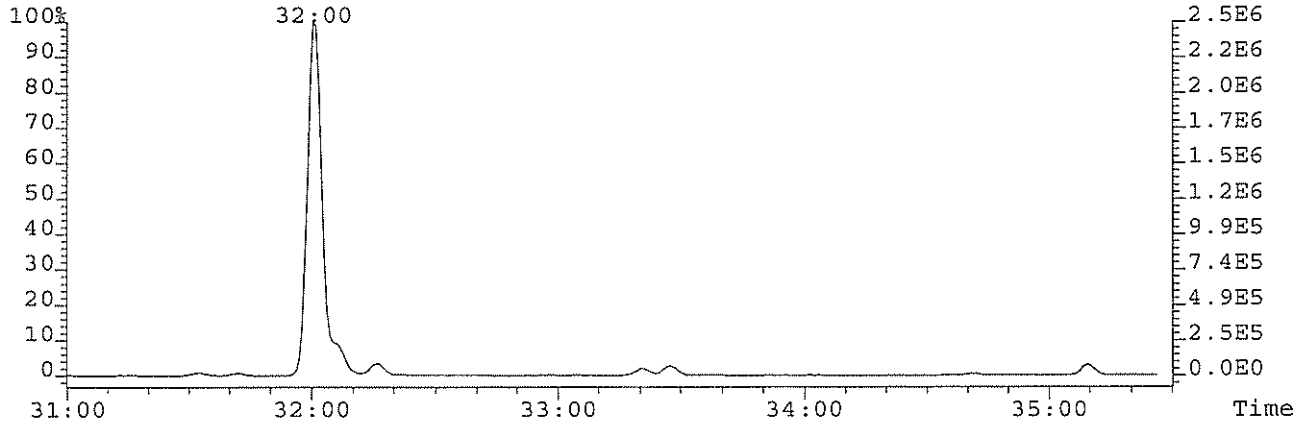


PeCDFsクロマトグラム (7)  
(23478-PeCDF)

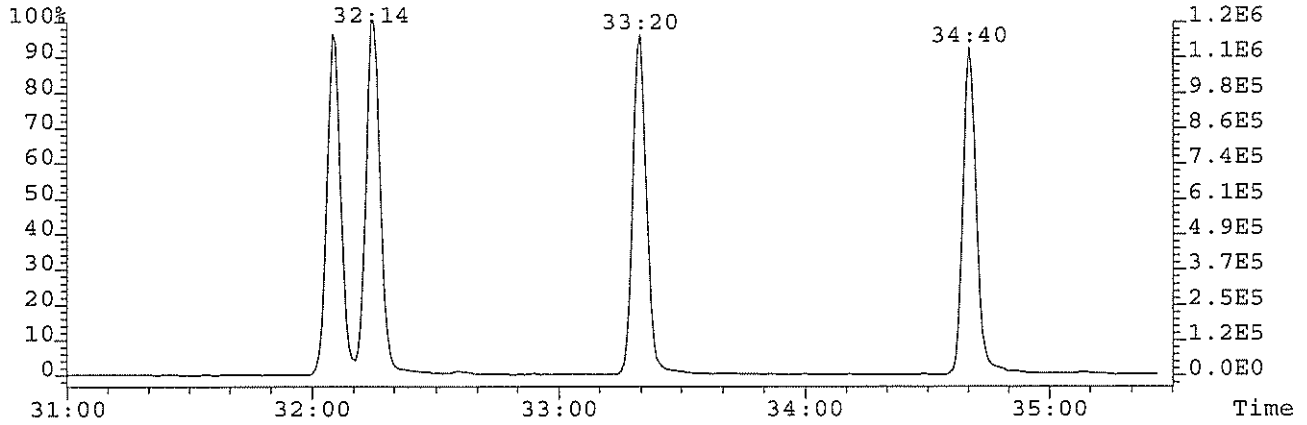
File:130713 #1-648 Acq:14-JUL-2013 03:55:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0966 3 Exp:RH-PD22  
373.8207 S:20 F:2 SMO(1,3)



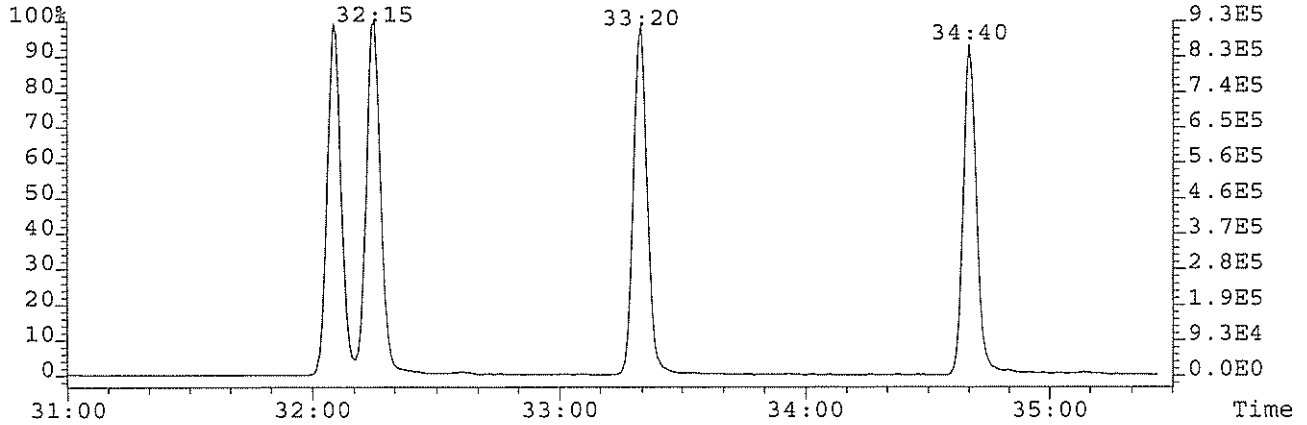
375.8178 S:20 F:2 SMO(1,3)



385.8610 S:20 F:2 SMO(1,3)

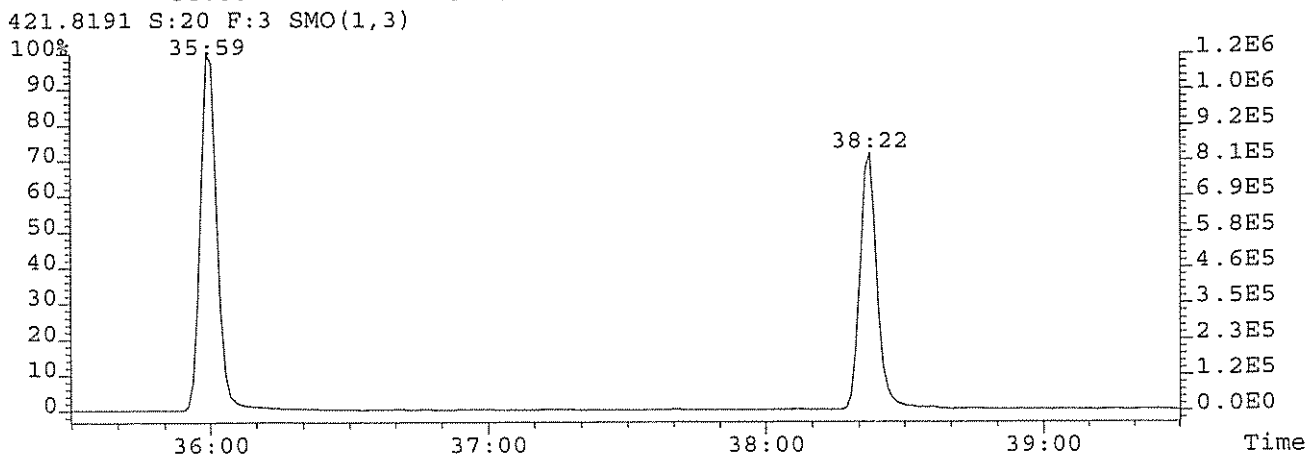
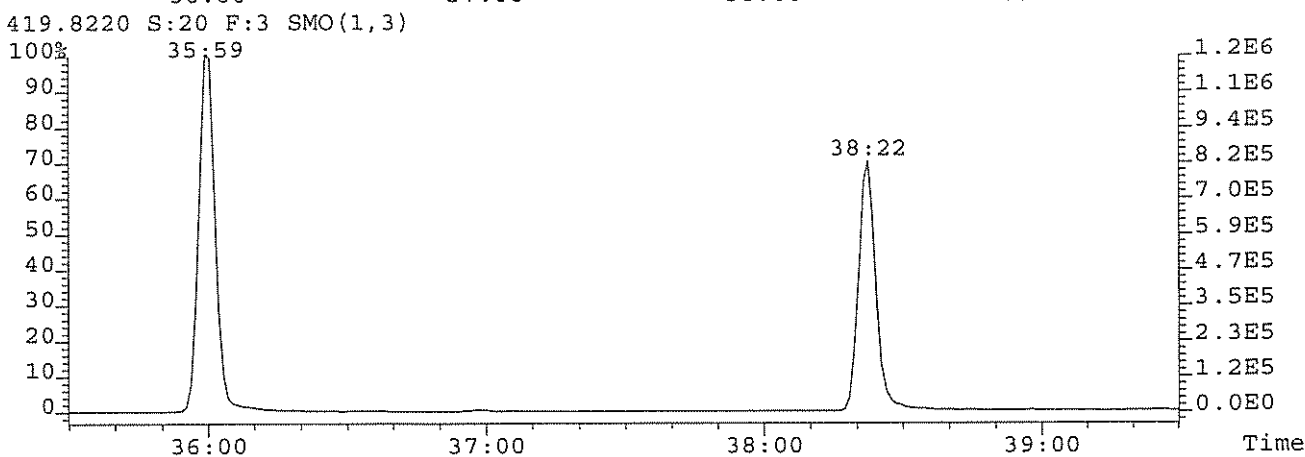
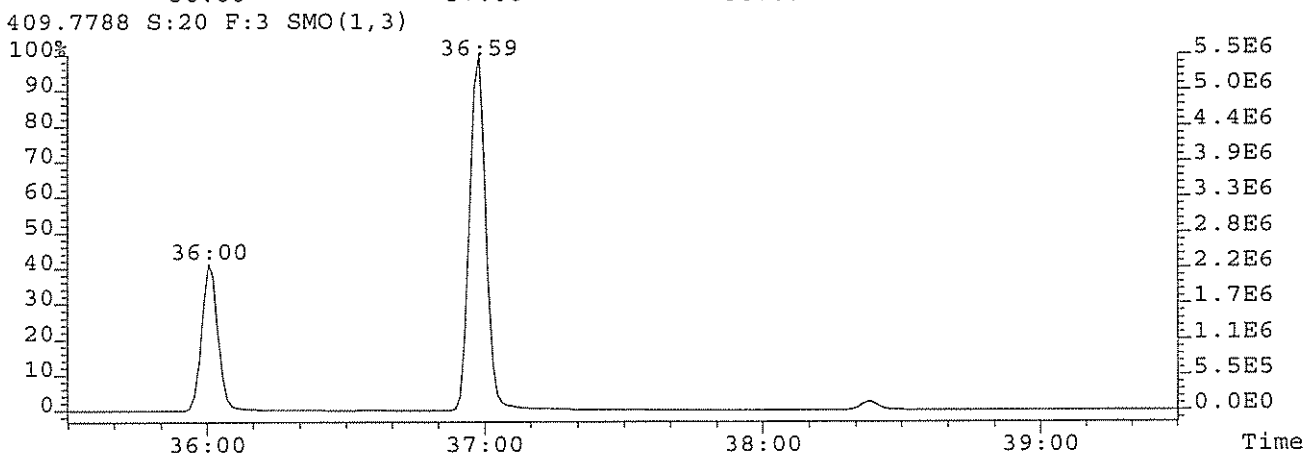
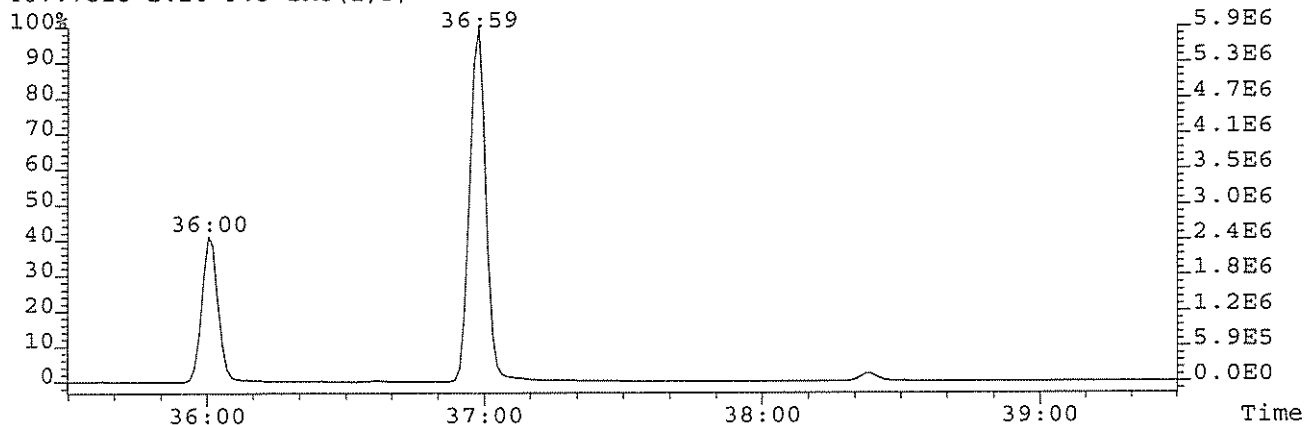


387.8580 S:20 F:2 SMO(1,3)



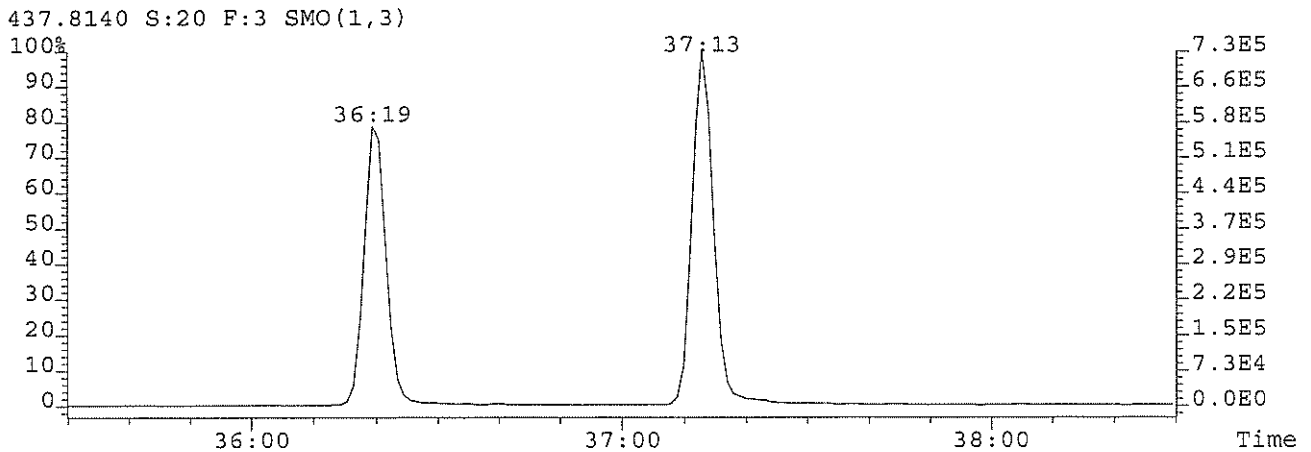
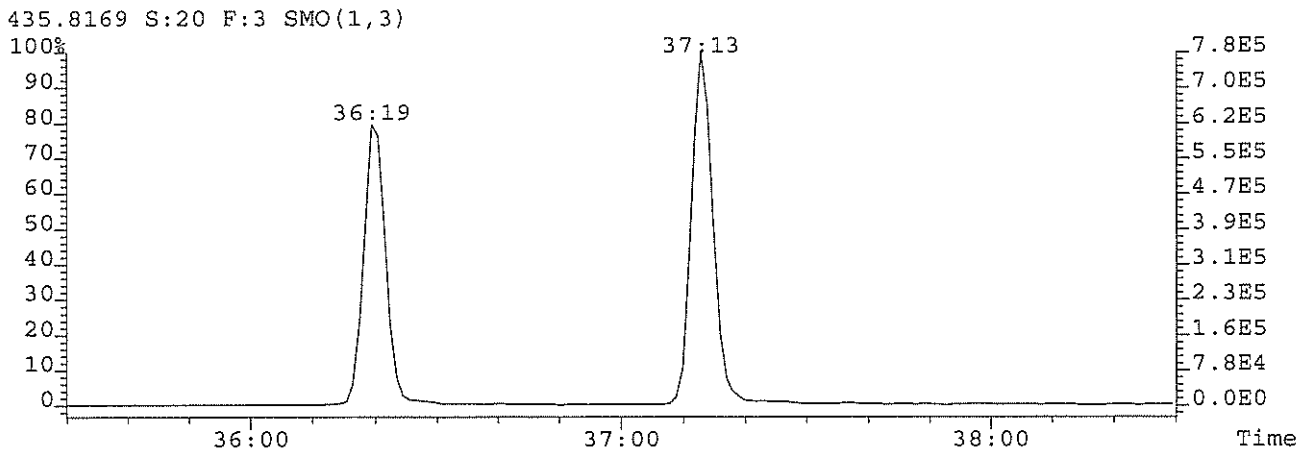
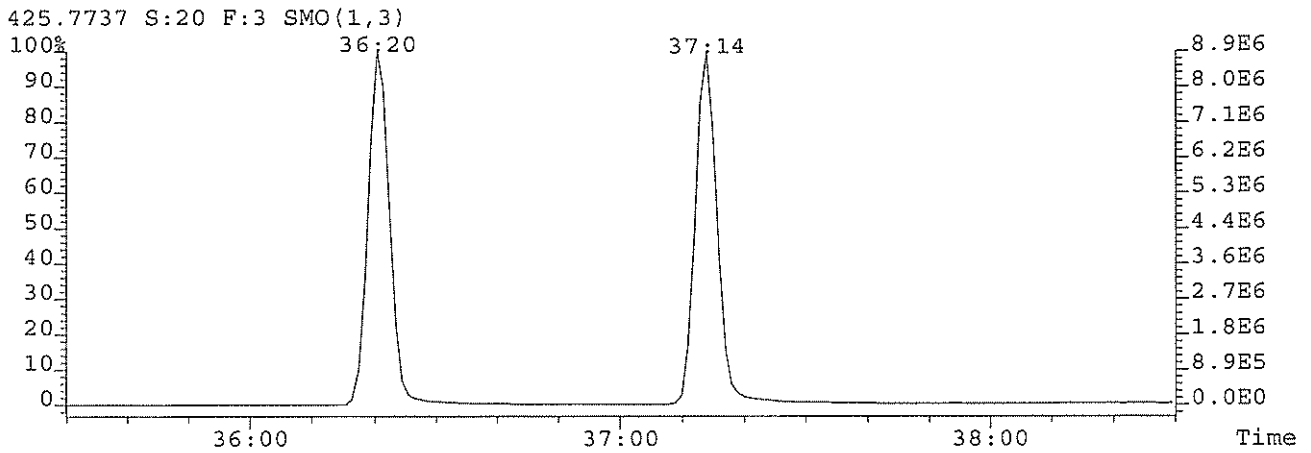
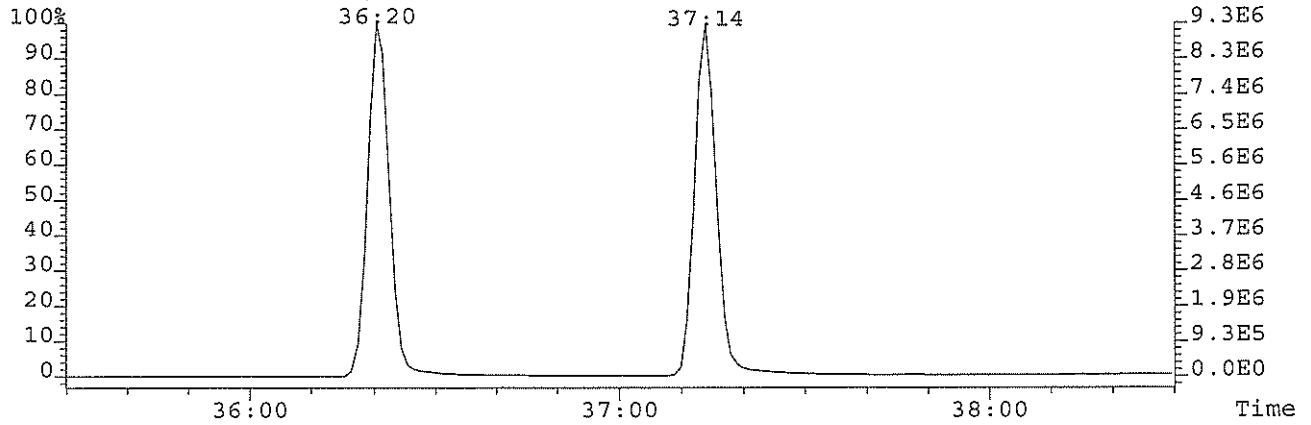


File:130713 #1-562 Acq:14-JUL-2013 03:55:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0966 3 Exp:RH-PD22  
407.7818 S:20 F:3 SMO(1,3)



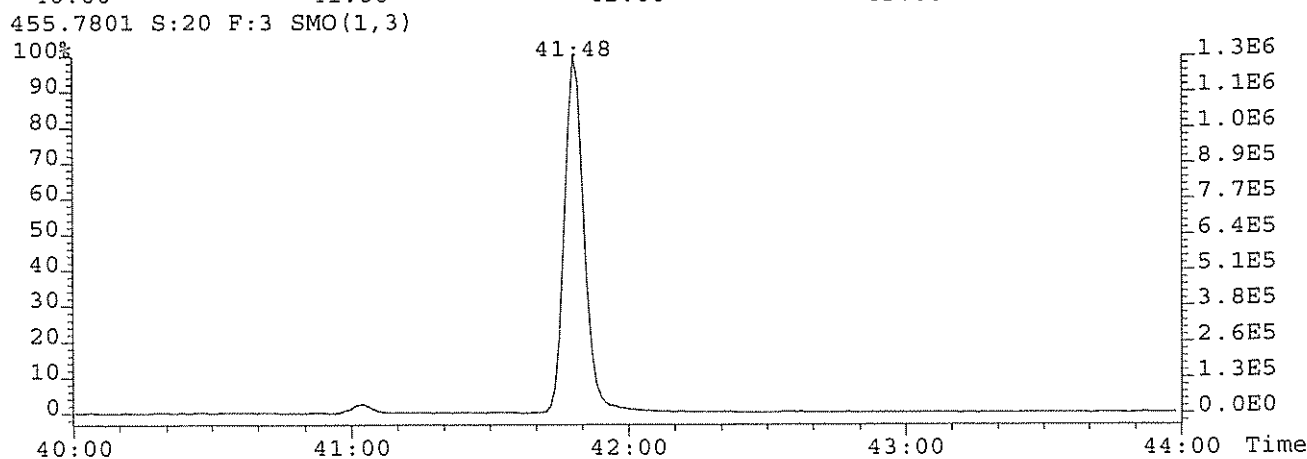
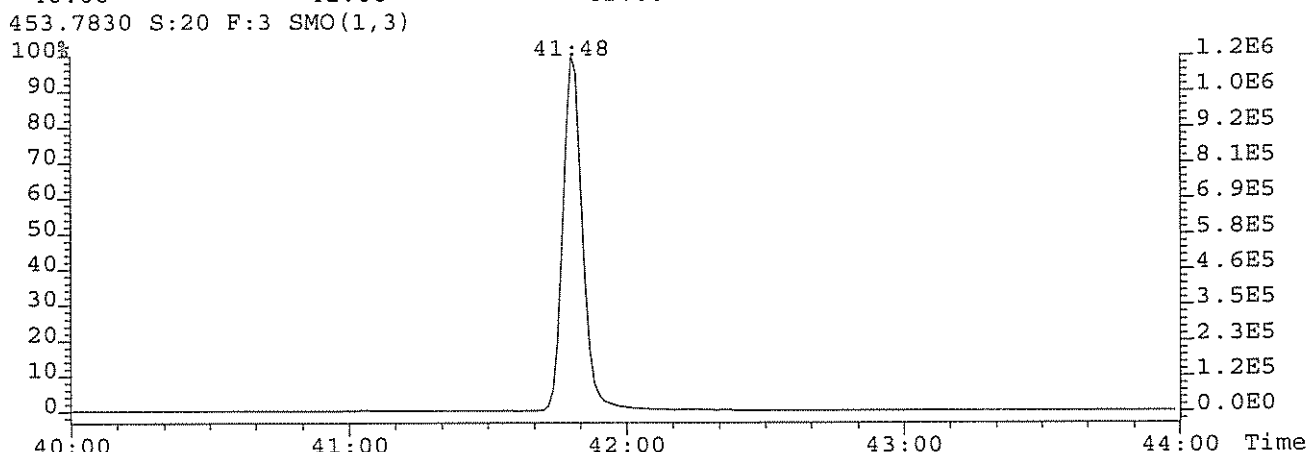
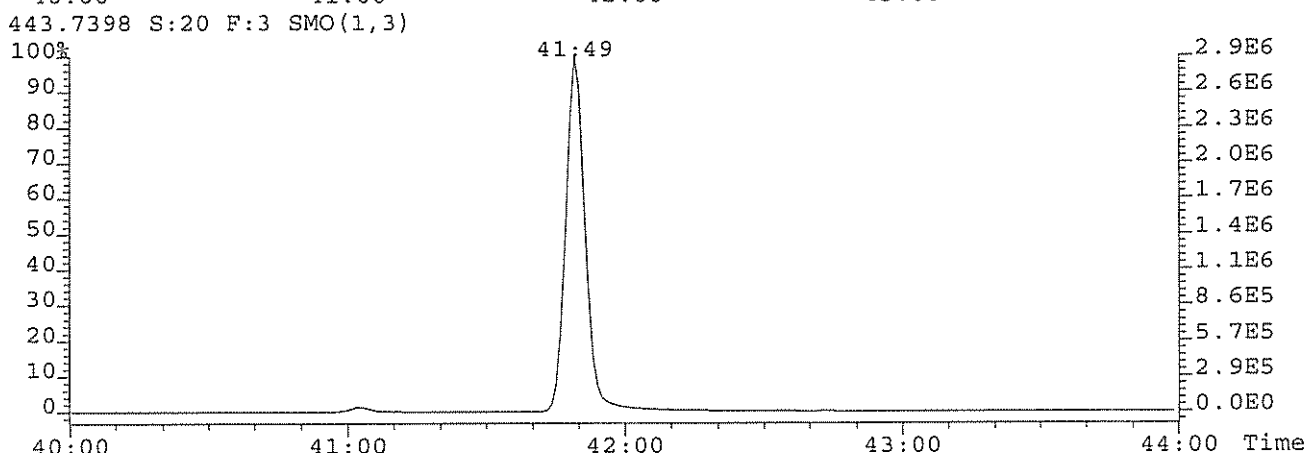
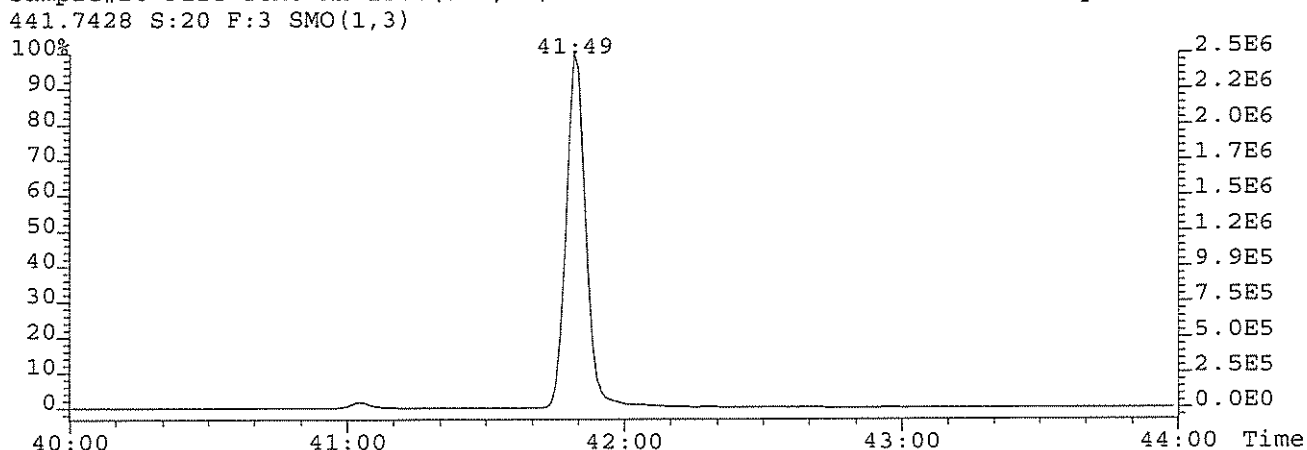
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130713 #1-562 Acq:14-JUL-2013 03:55:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0966 3 Exp:RH-PD22  
423.7767 S:20 F:3 SMO(1,3)



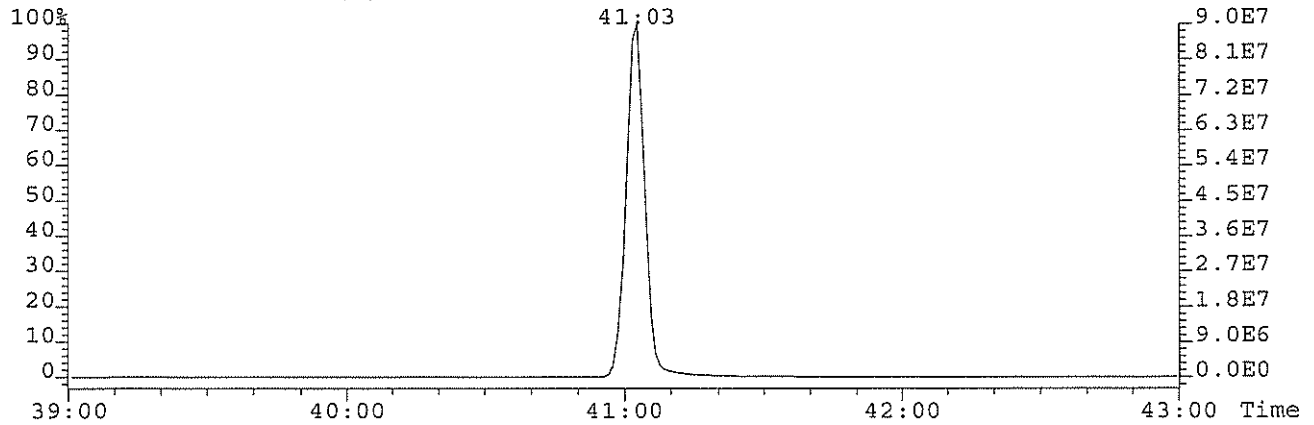
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130713 #1-562 Acq:14-JUL-2013 03:55:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0966 3 Exp:RH-PD22

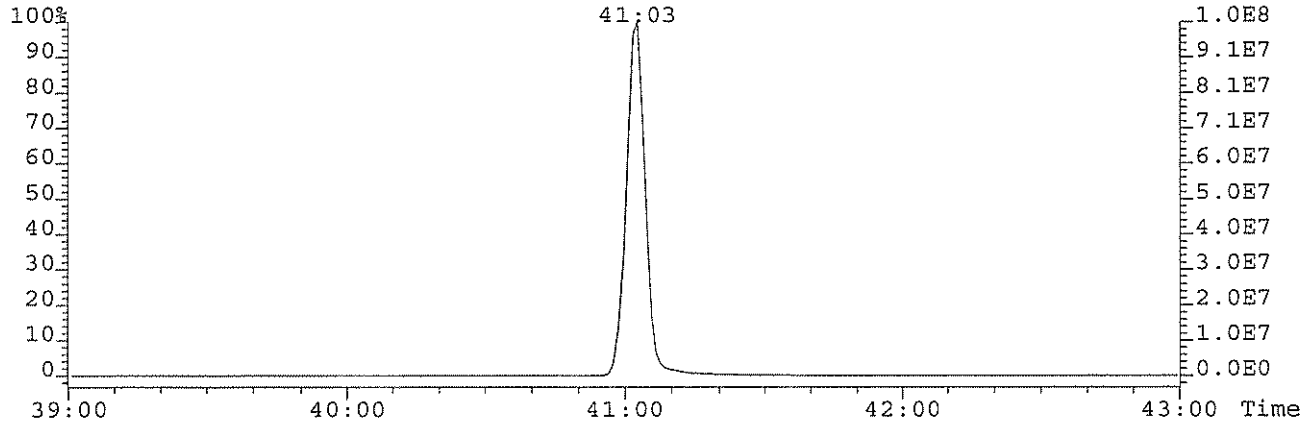


PCDFsクロマトグラム (11)  
(OCDF)

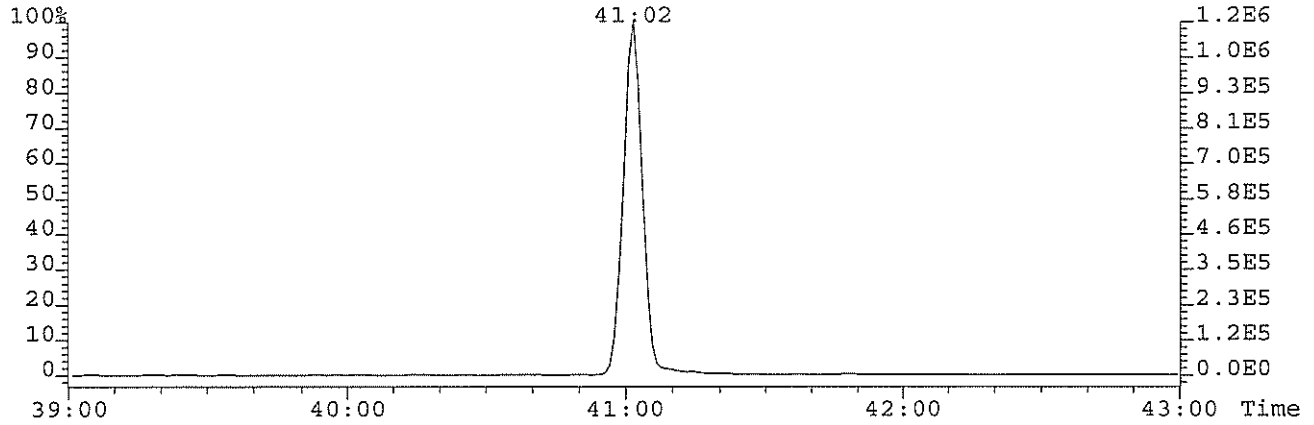
File:130713 #1-562 Acq:14-JUL-2013 03:55:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0966 3 Exp:RH-PD22  
457.7377 S:20 F:3 SMO(1,3)



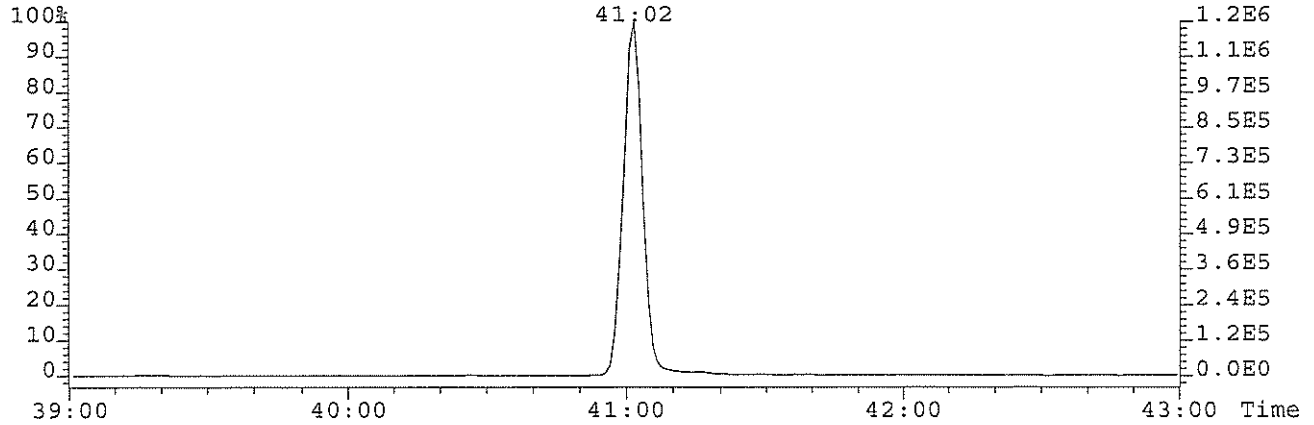
459.7348 S:20 F:3 SMO(1,3)



469.7780 S:20 F:3 SMO(1,3)

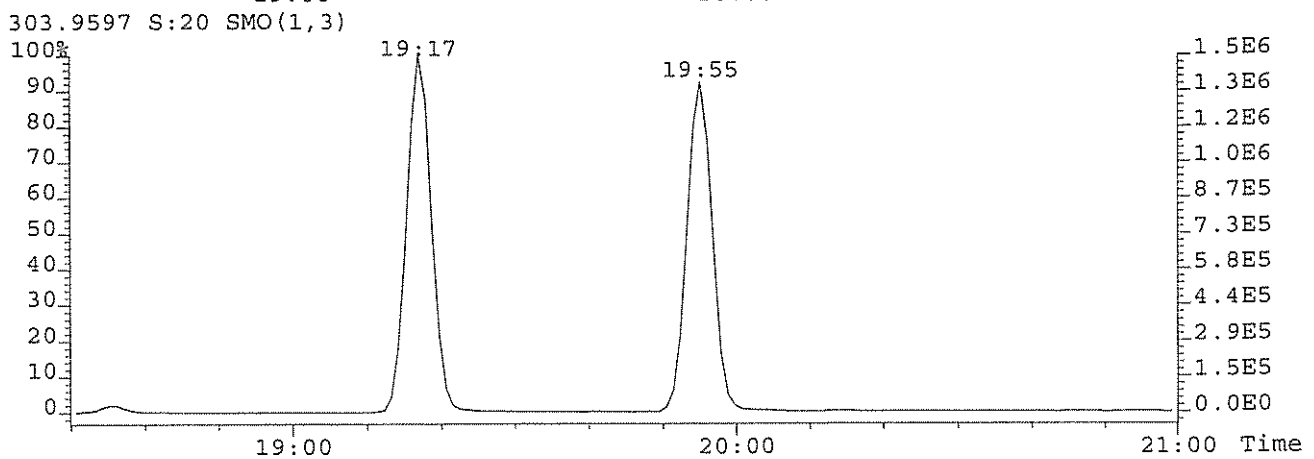
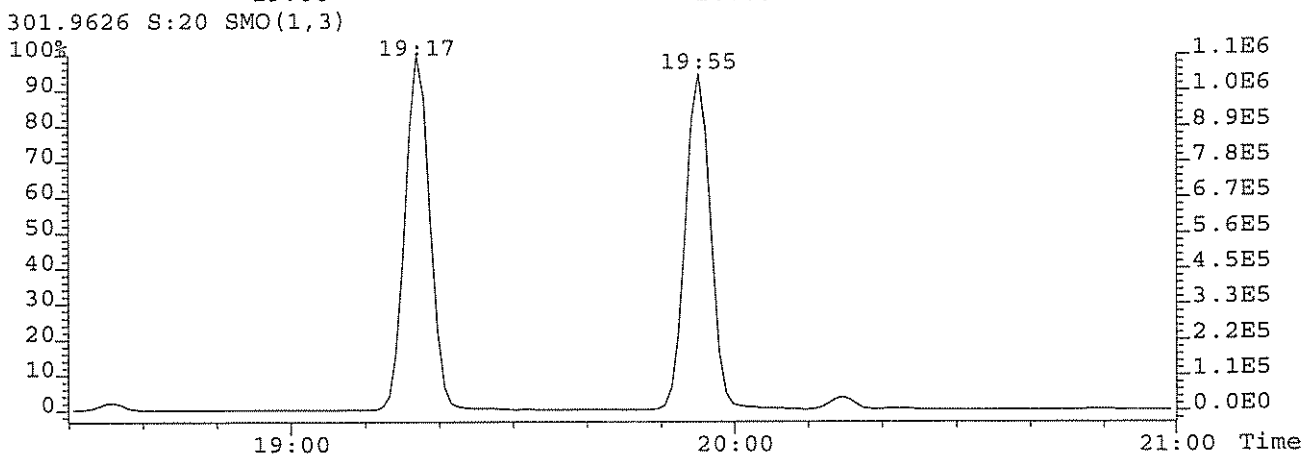
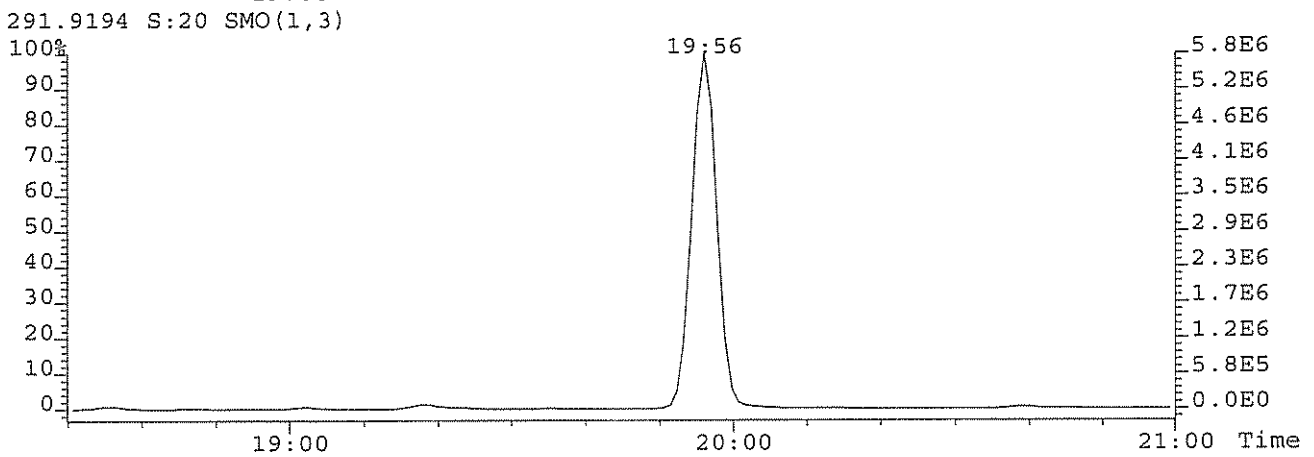
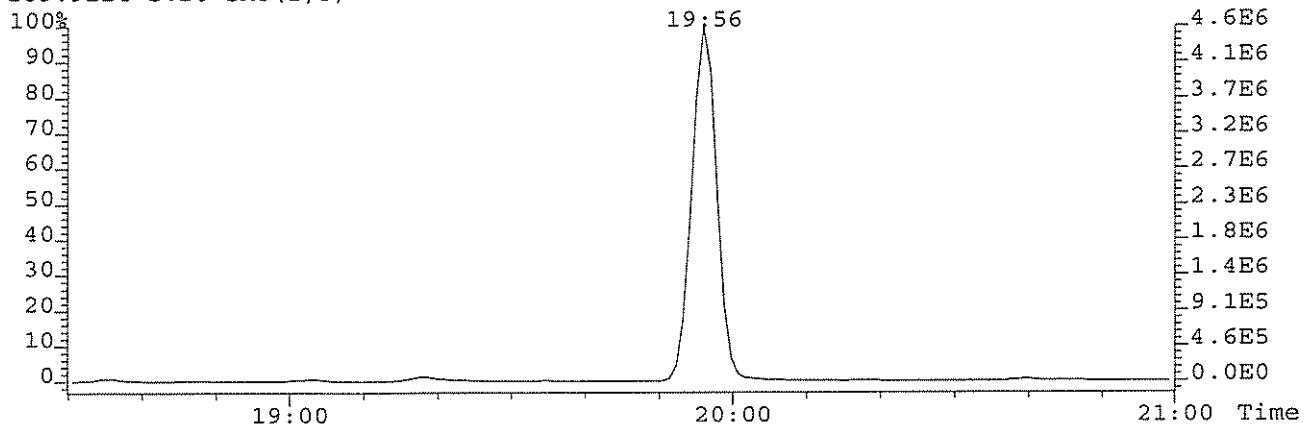


471.7750 S:20 F:3 SMO(1,3)



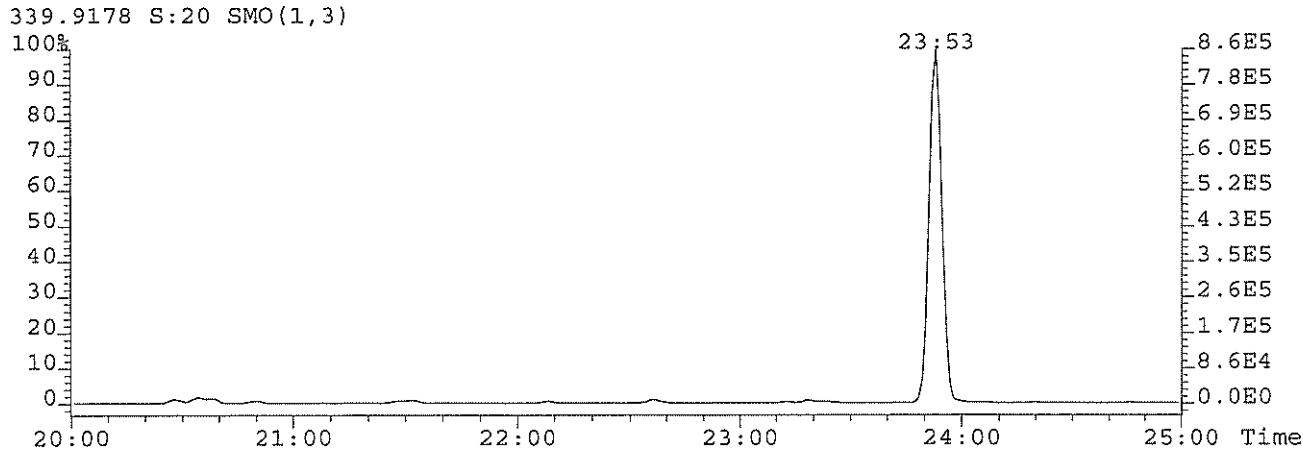
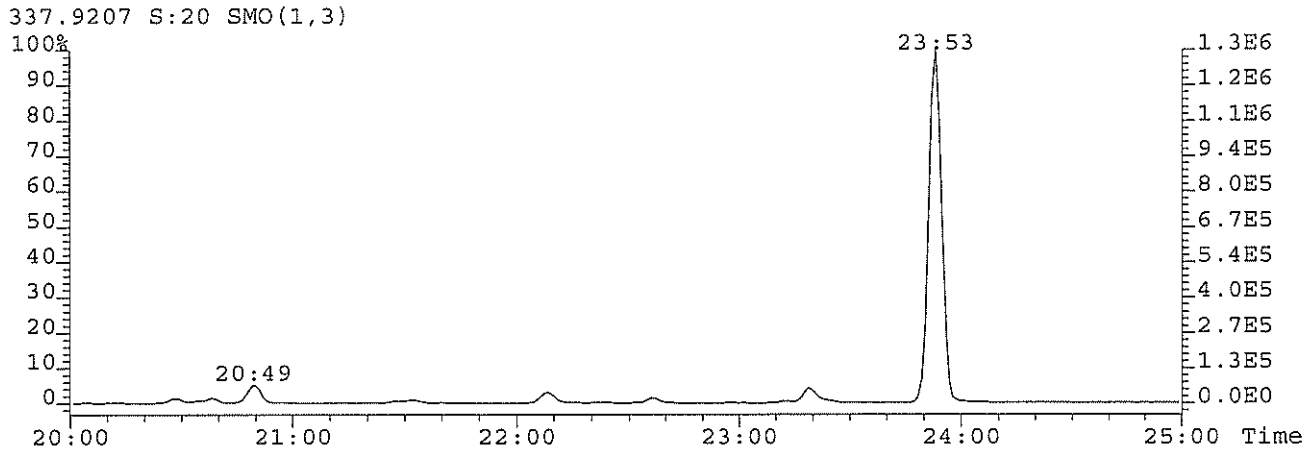
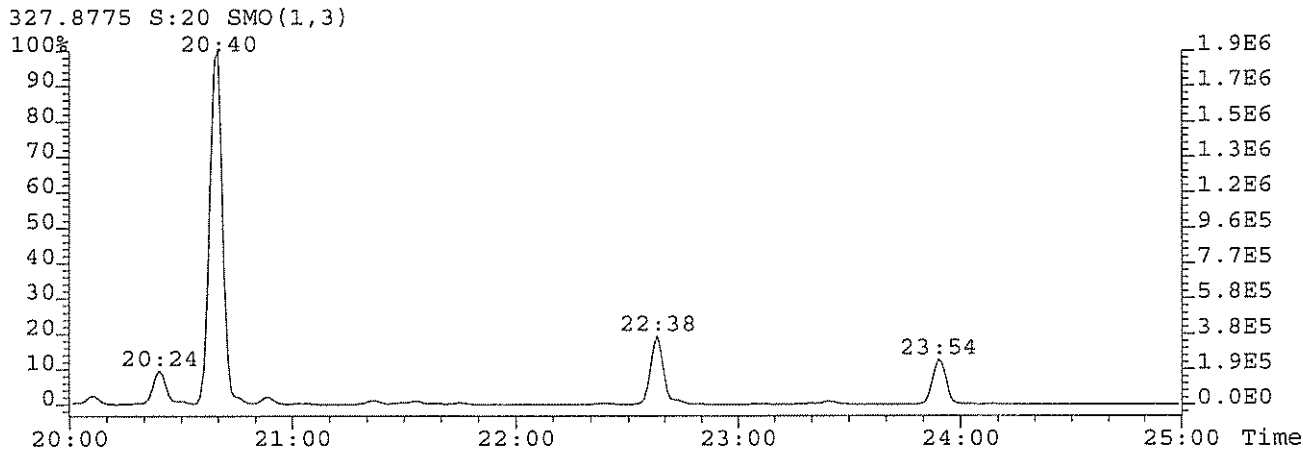
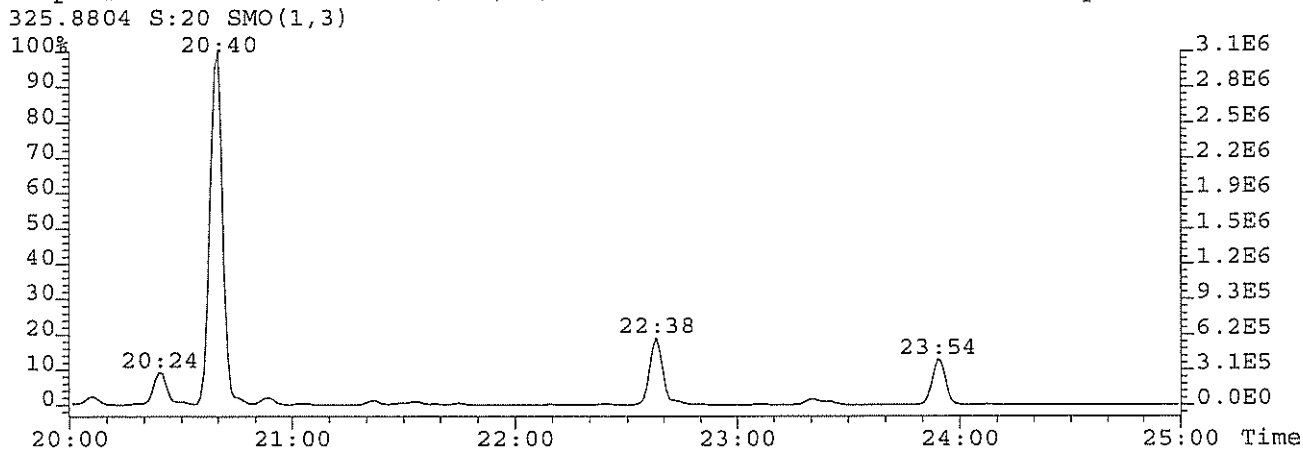
PCDDsクロマトグラム (12)  
(OCDD)

File:130713 #1-1430 Acq:14-JUL-2013 03:55:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0966 3 Exp:RH-PD22  
289.9224 S:20 SMO(1,3)



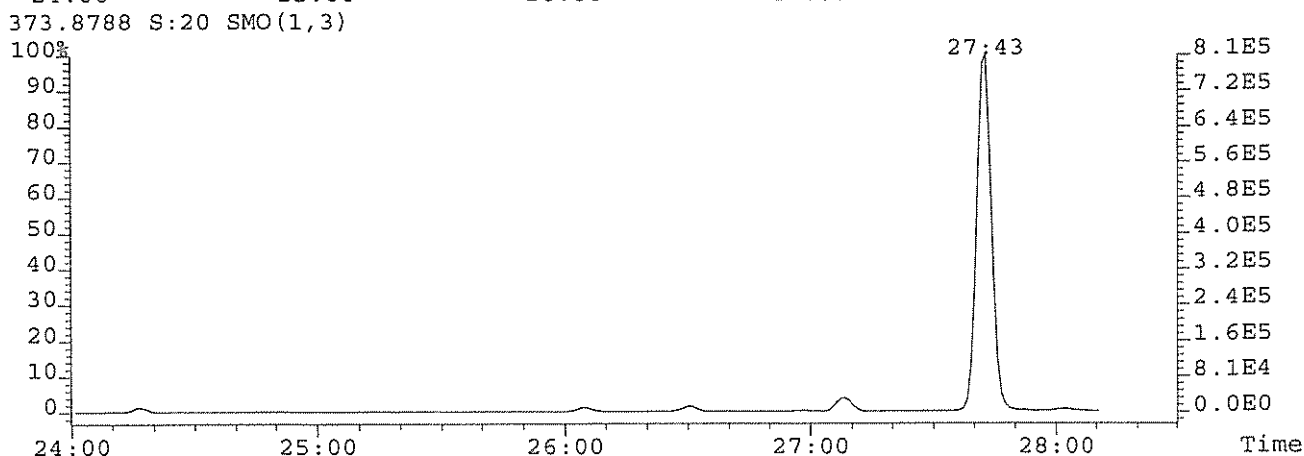
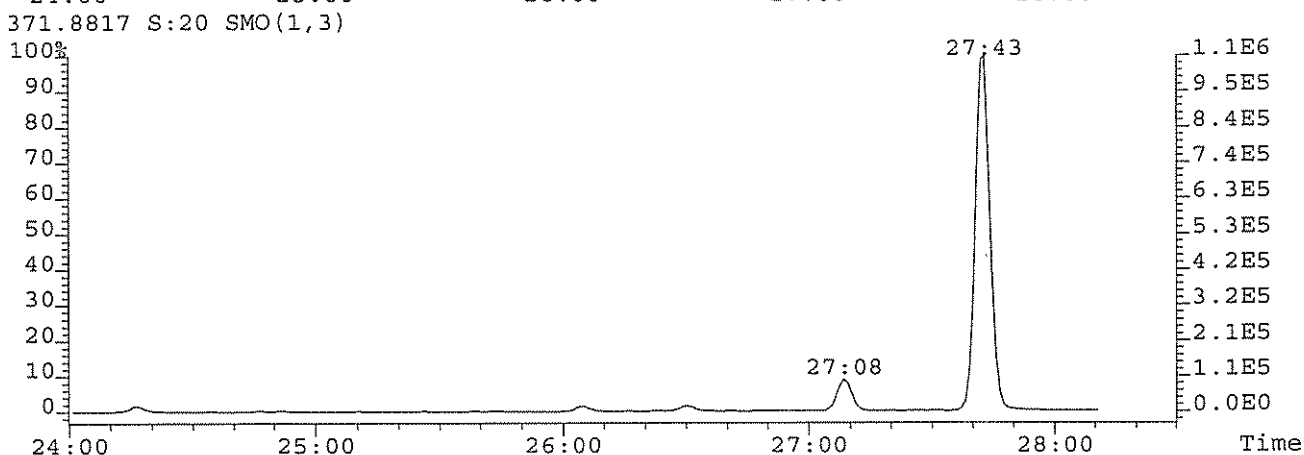
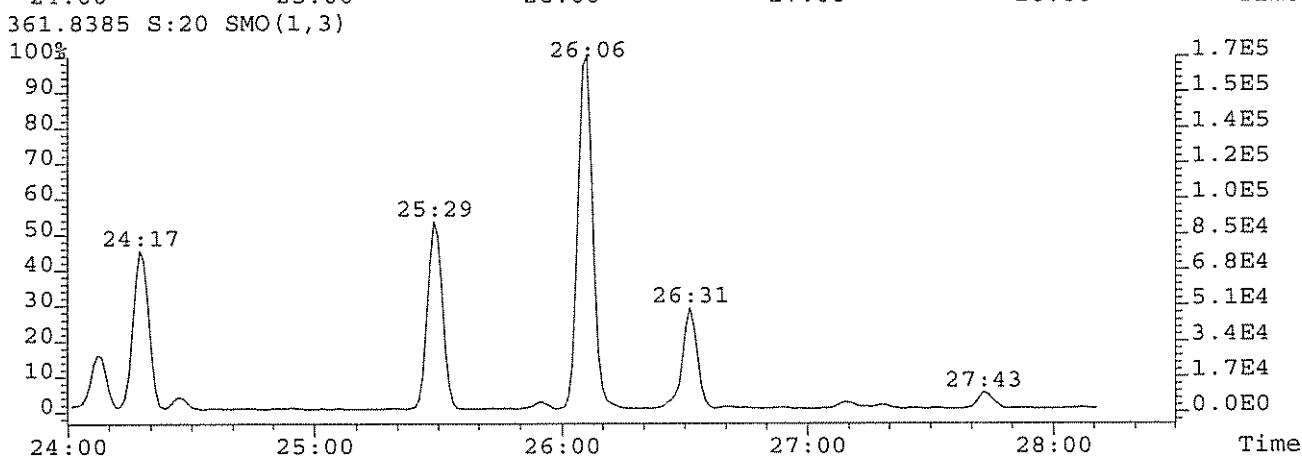
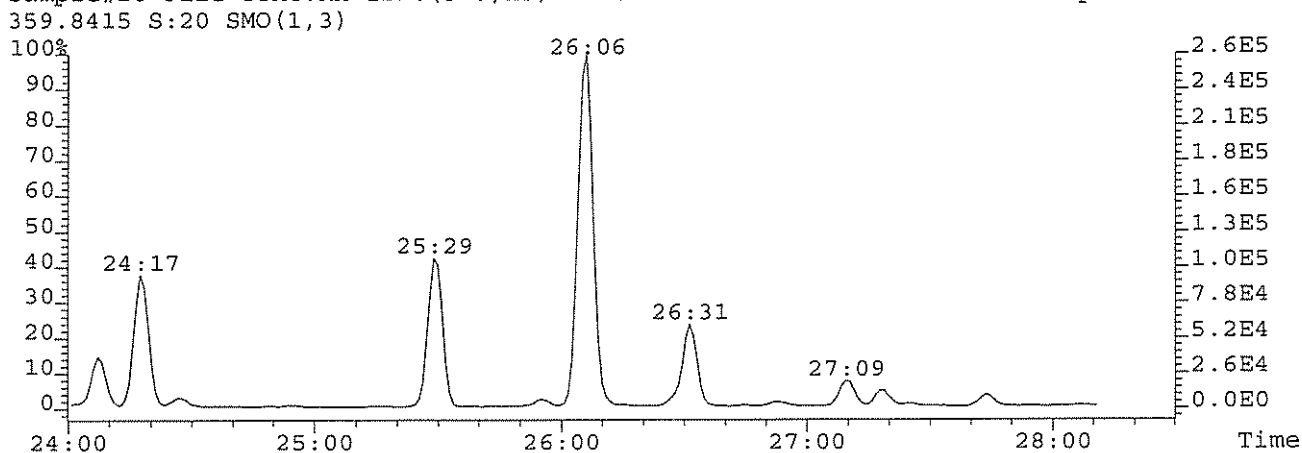
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130713 #1-1430 Acq:14-JUL-2013 03:55:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0966 3 Exp:RH-PD22



DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

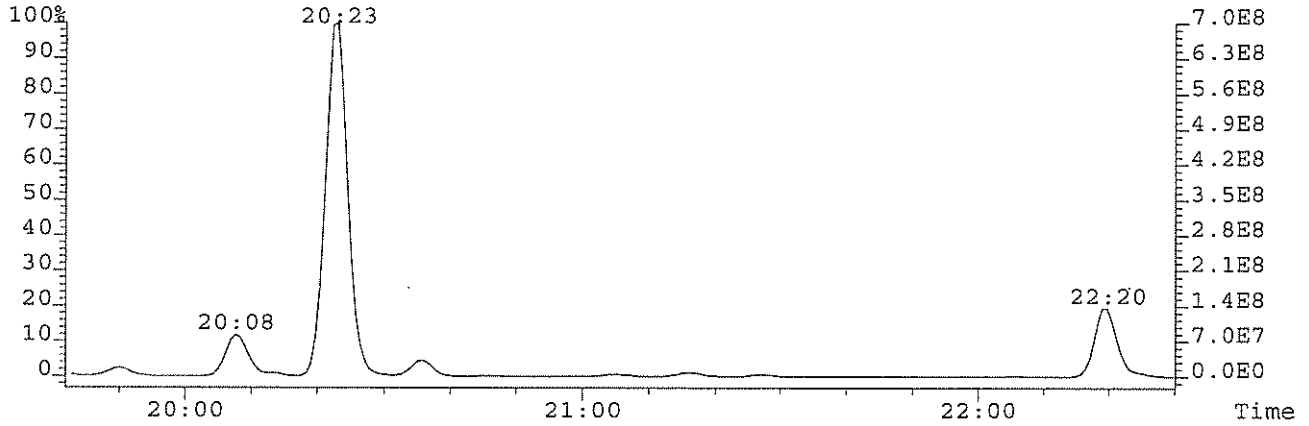
File:130713 #1-1430 Acq:14-JUL-2013 03:55:05 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(5-8,nP) Text:XE13 0966 3 Exp:RH-PD22



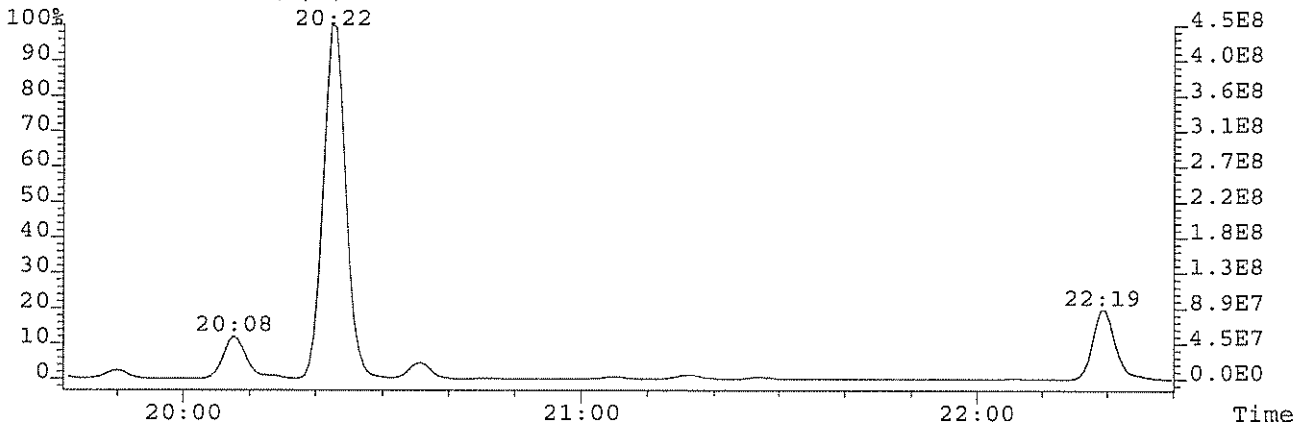
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130713 #1-2898 Acq:14-JUL-2013 00:35:54 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(mP) Text:XE13 0966 2 Exp:RH-MP11

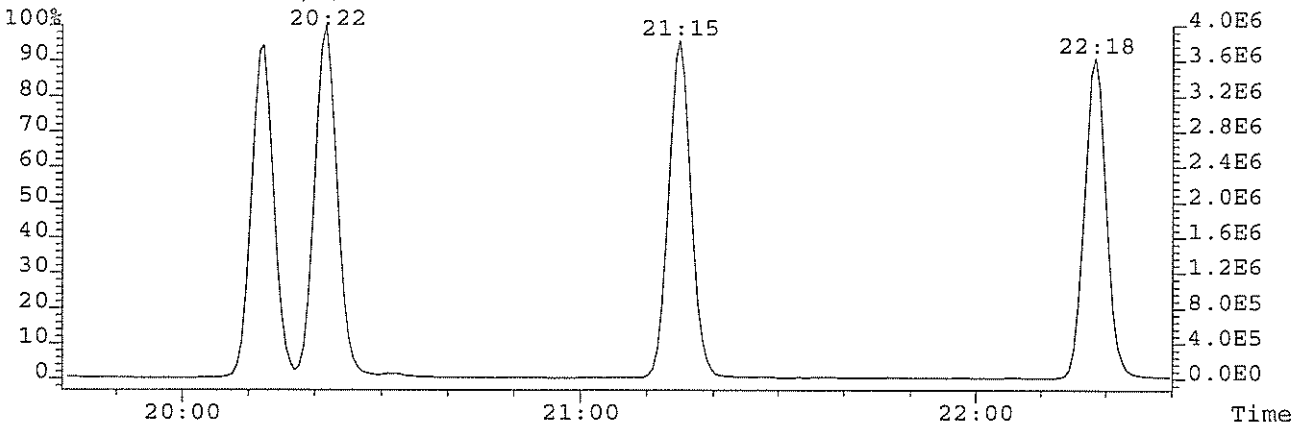
325.8804 S:19 SMO(1,3)



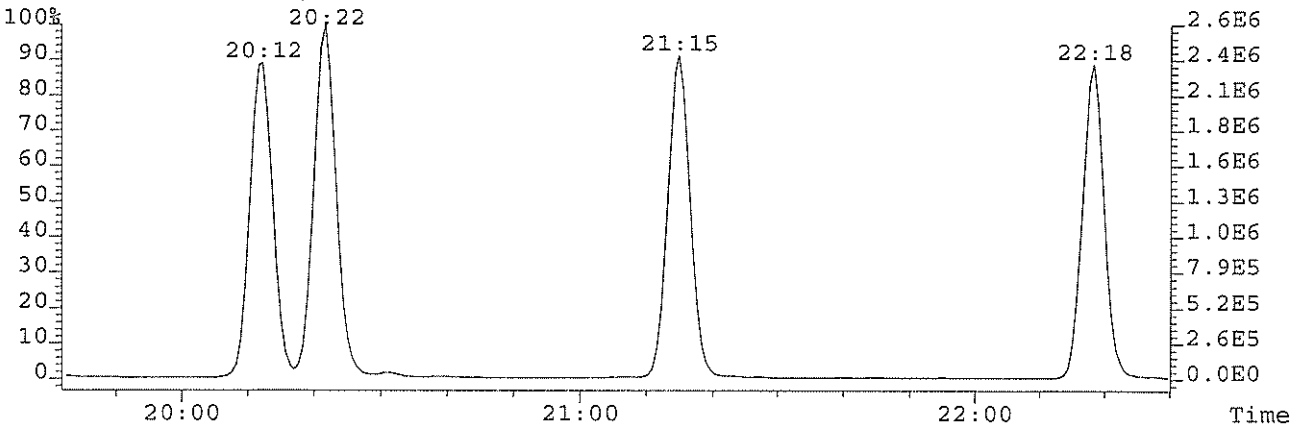
327.8775 S:19 SMO(1,3)



337.9207 S:19 SMO(1,3)



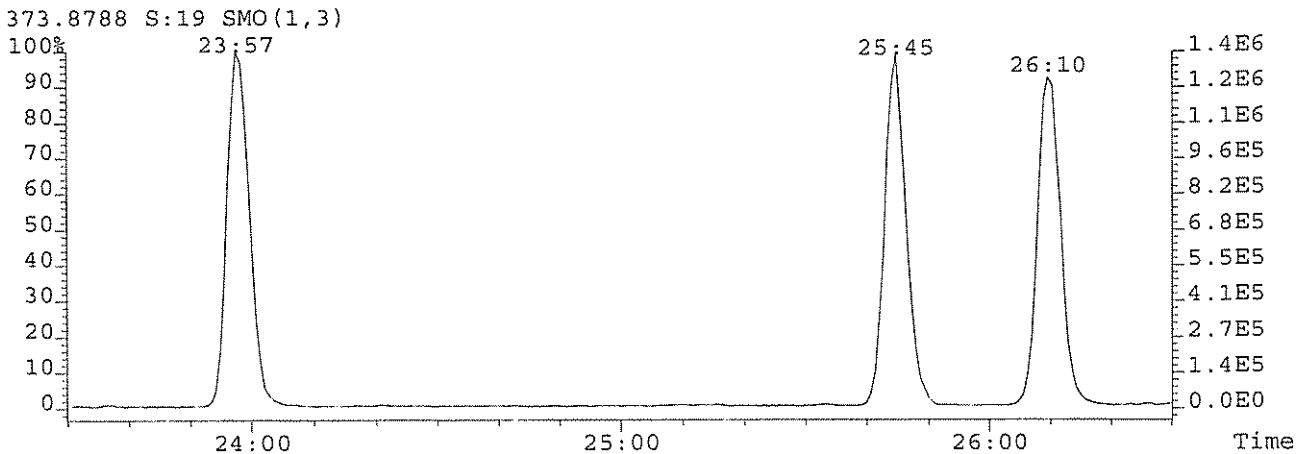
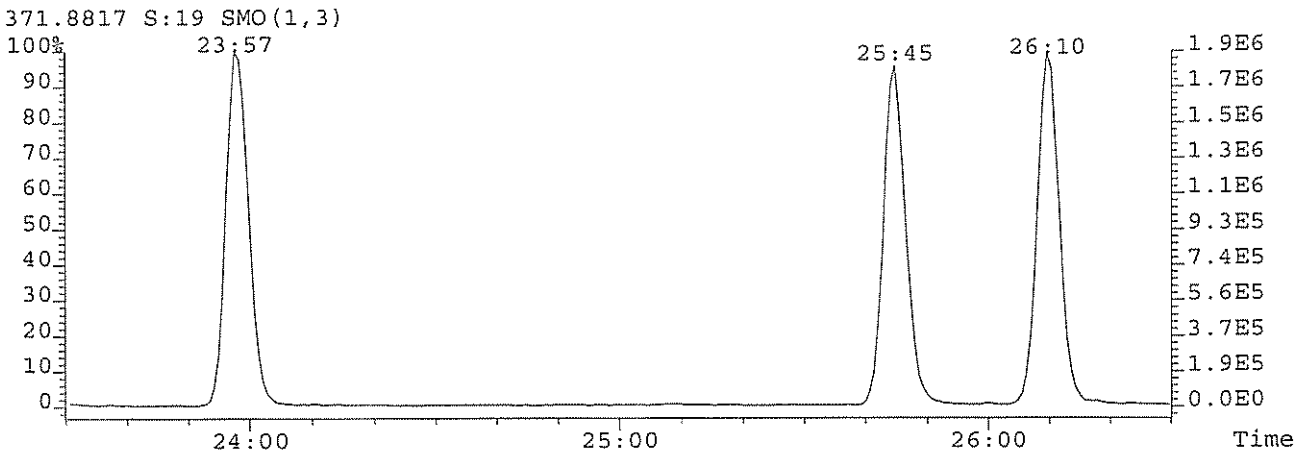
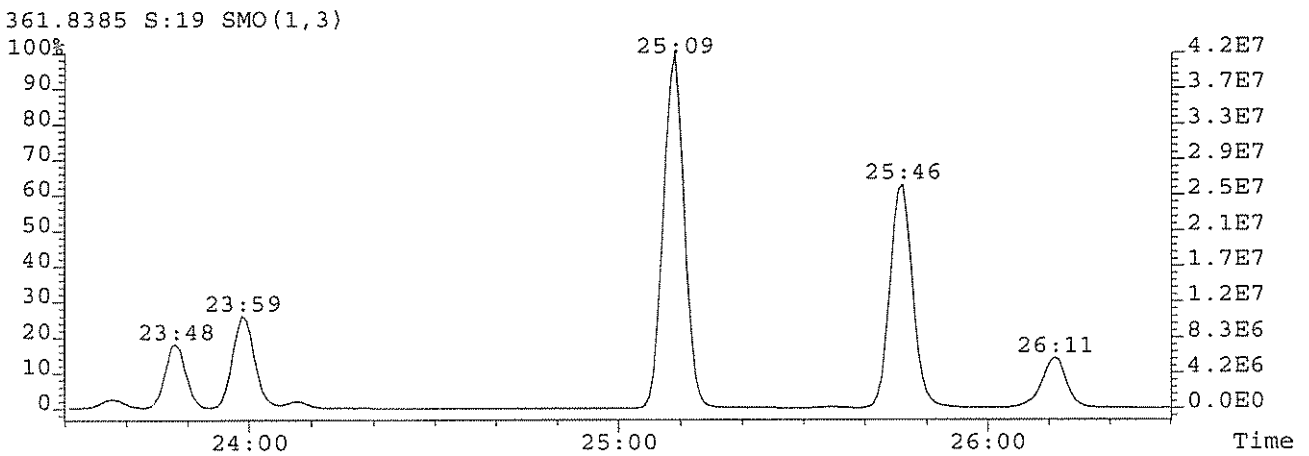
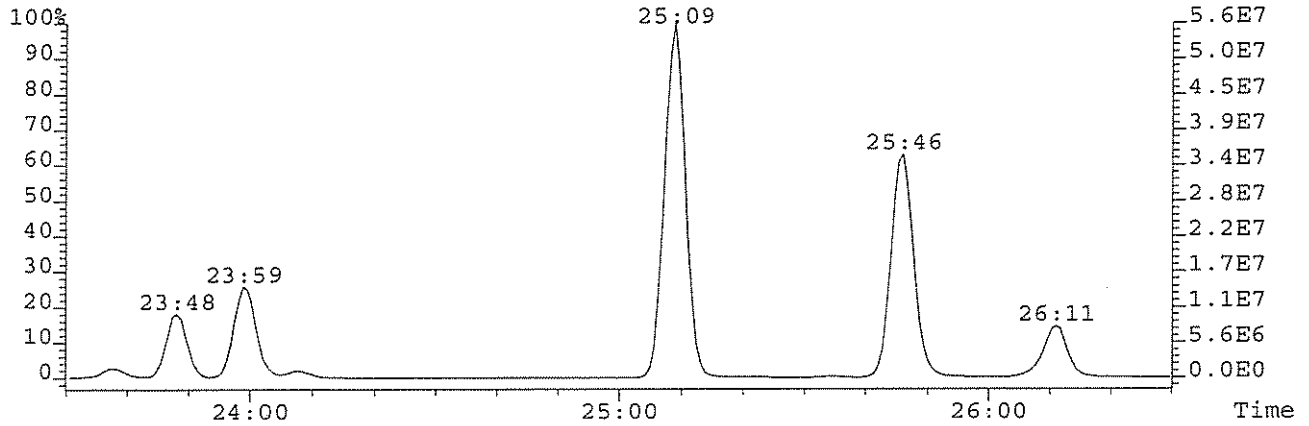
339.9178 S:19 SMO(1,3)



DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

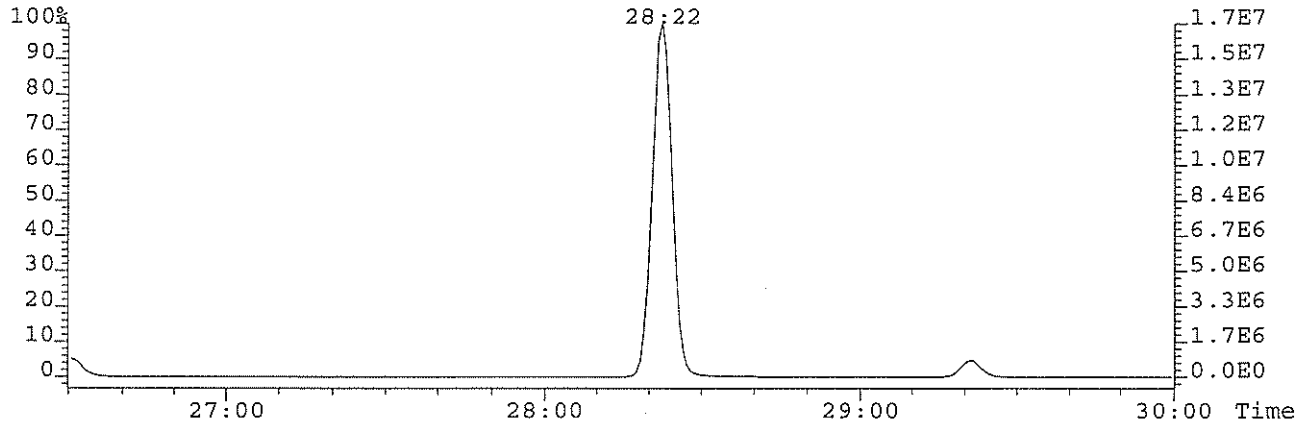


File:130713 #1-2898 Acq:14-JUL-2013 00:35:54 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(mP) Text:XE13 0966 2 Exp:RH-MP11  
359.8415 S:19 SMO(1,3)

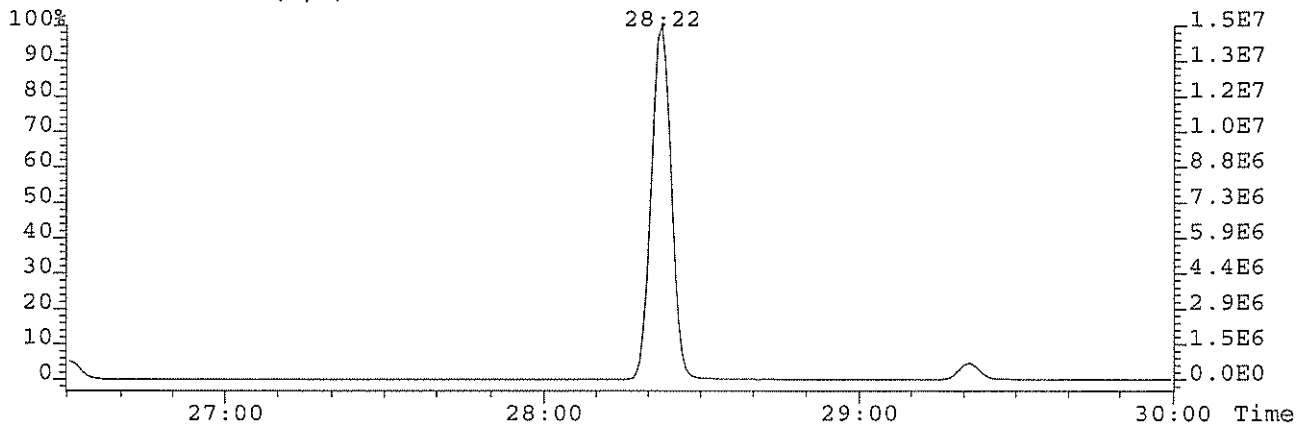


DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

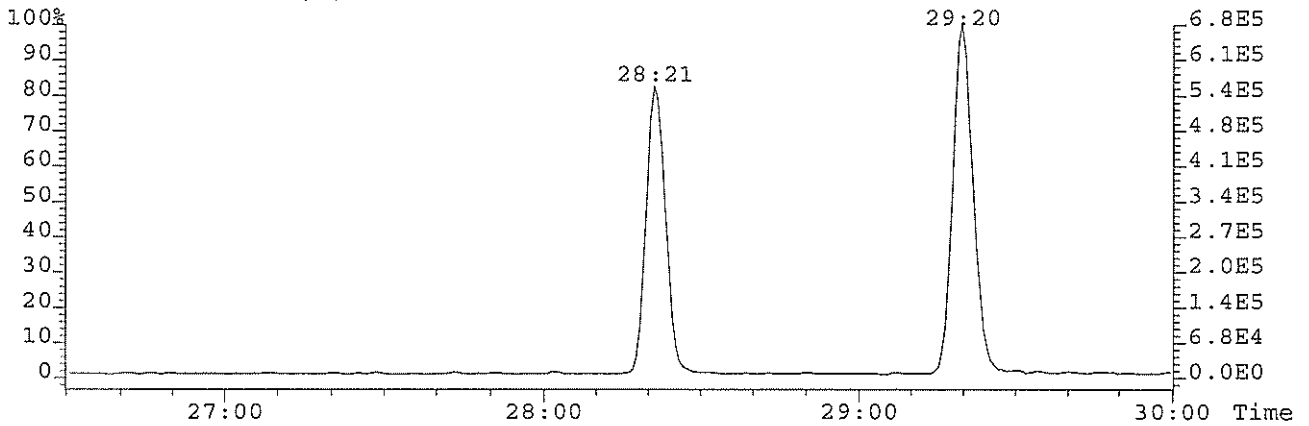
File:130713 #1-2898 Acq:14-JUL-2013 00:35:54 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#19 File Text:RH-12ms(mP) Text:XE13 0966 2 Exp:RH-MP11  
393.8025 S:19 SMO(1,3)



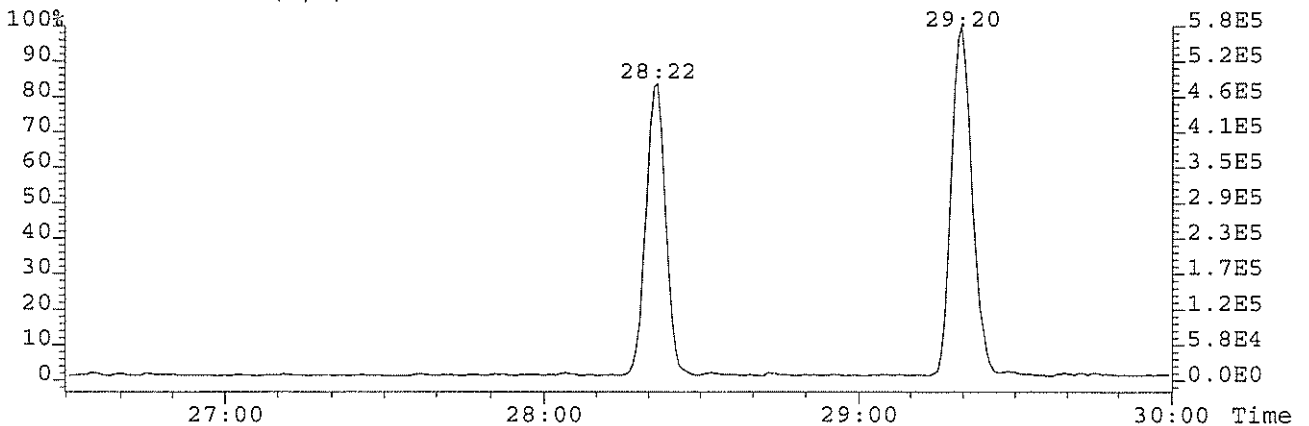
395.7995 S:19 SMO(1,3)



405.8428 S:19 SMO(1,3)



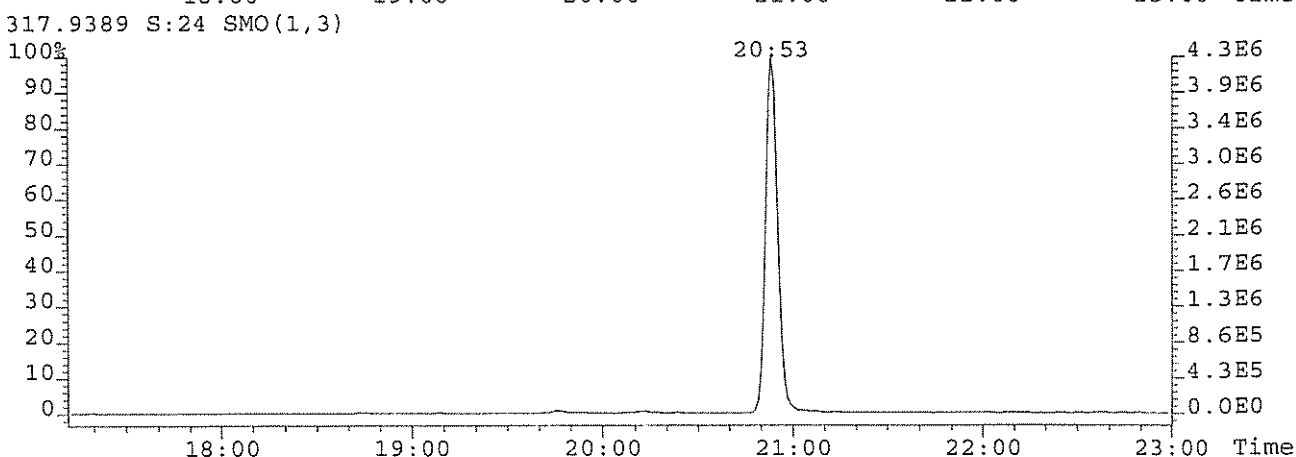
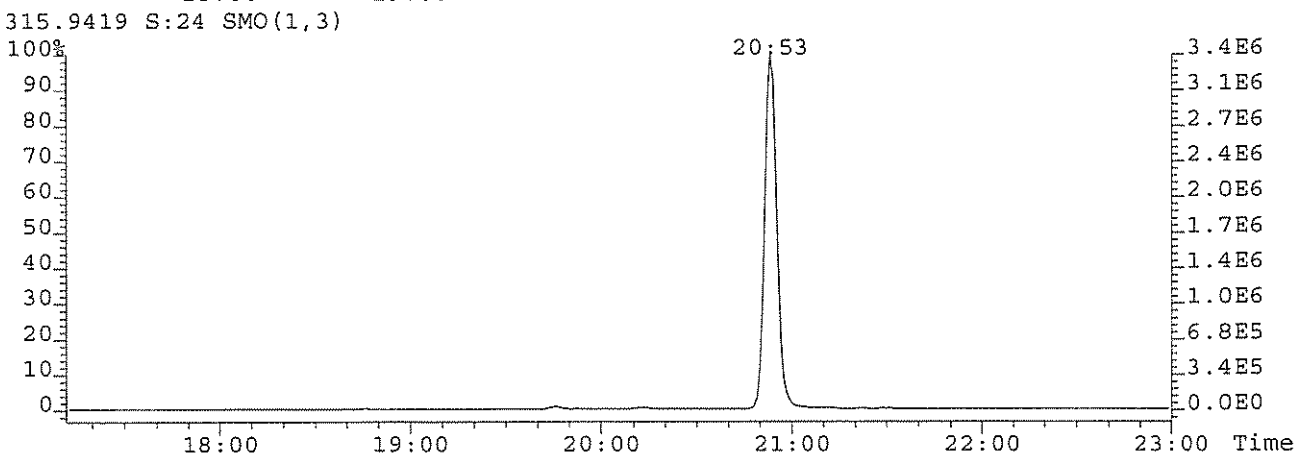
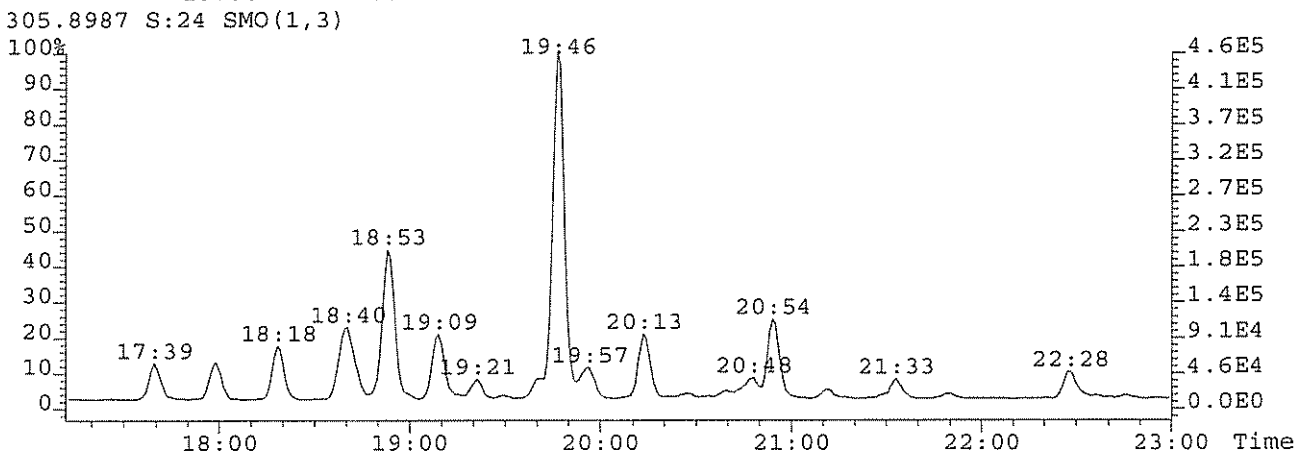
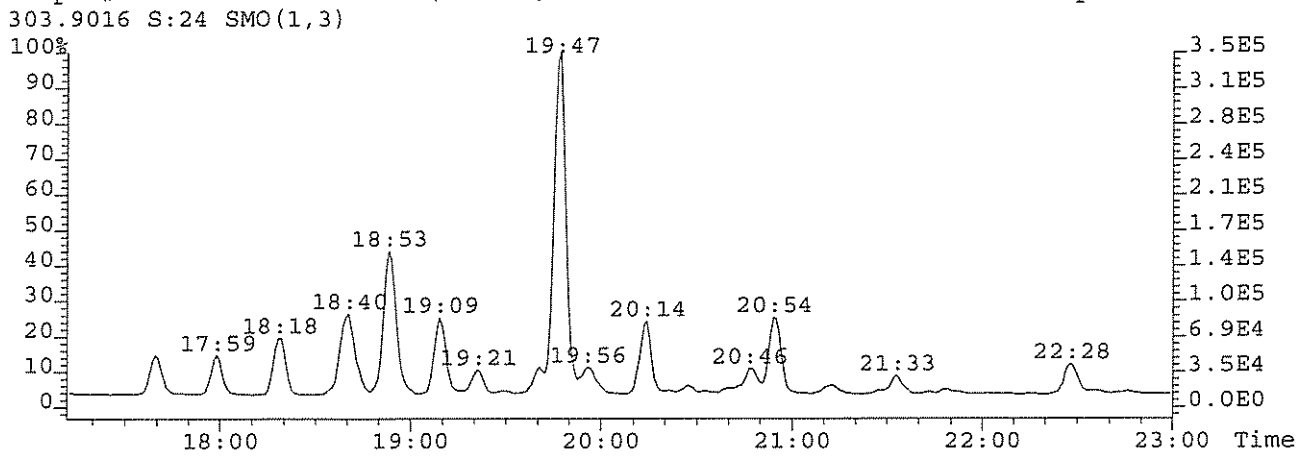
407.8398 S:19 SMO(1,3)



DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

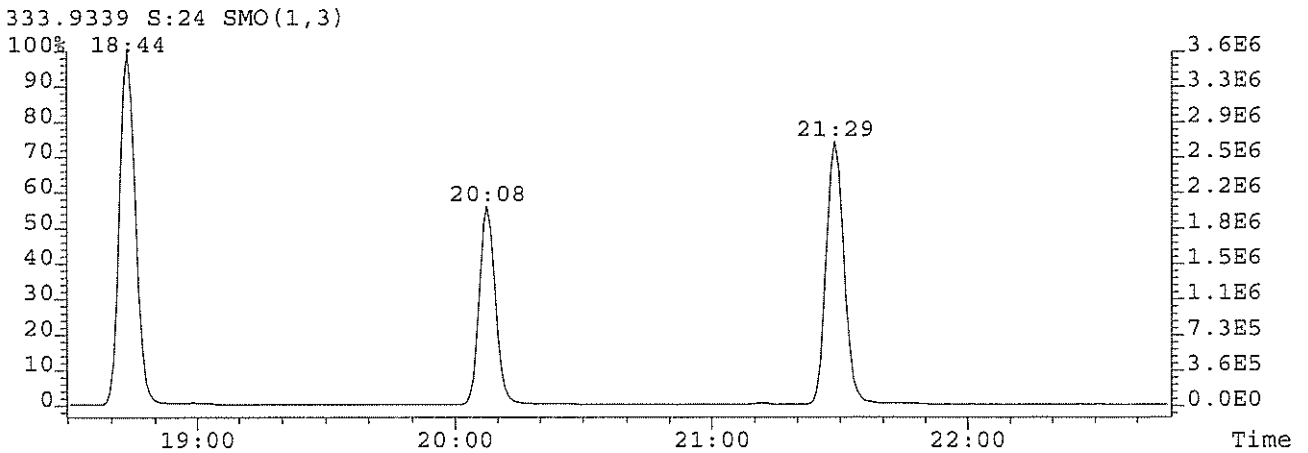
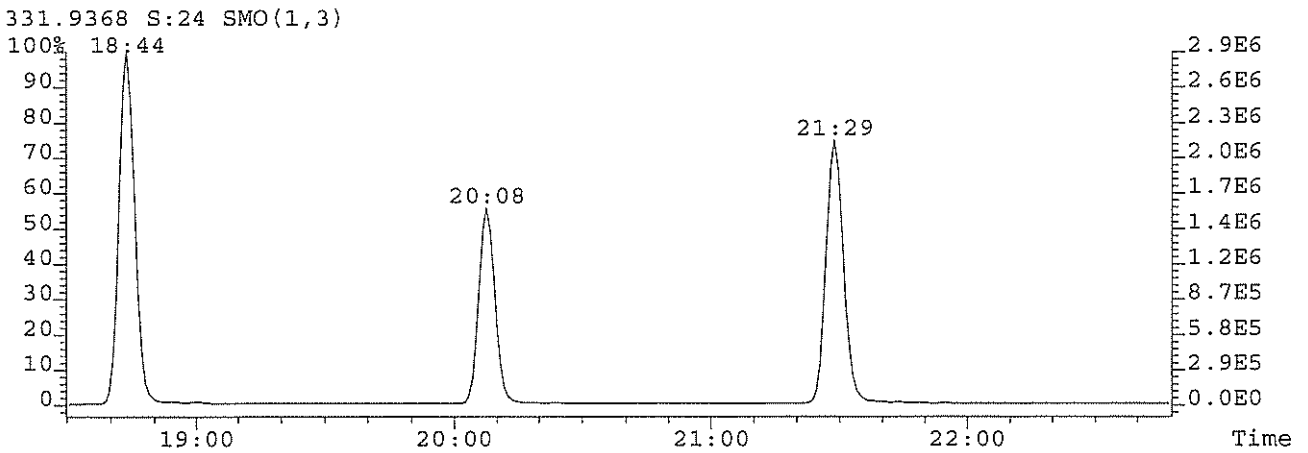
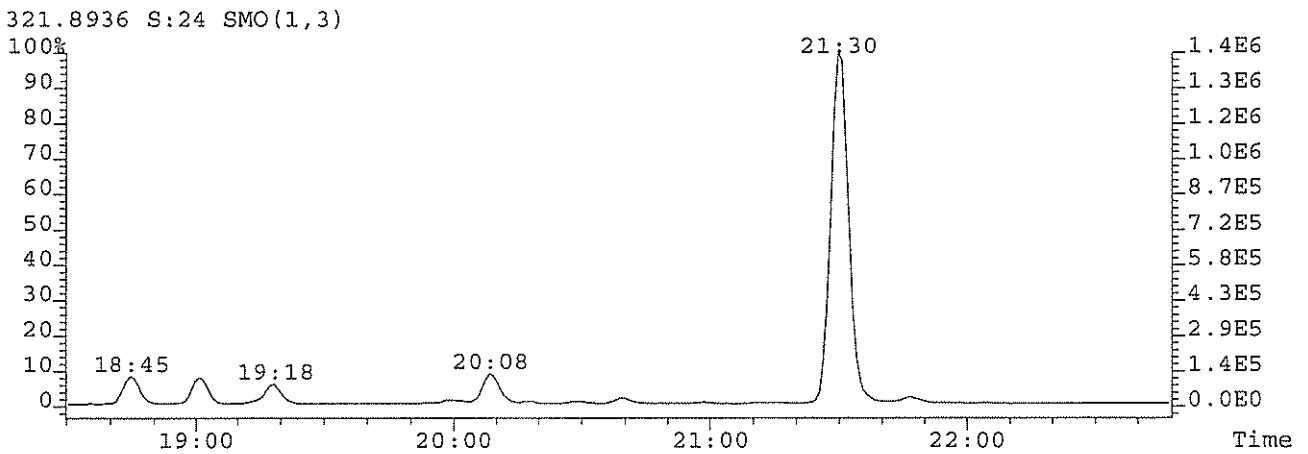
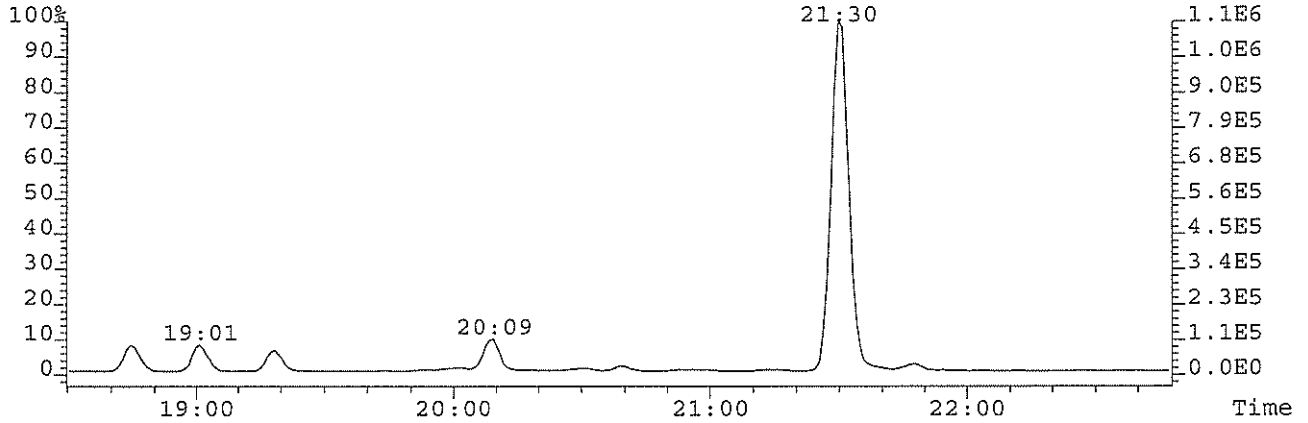
試料管理番号	XE 130967
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.21

File:130712-2 #1-1578 Acq:13-JUL-2013 10:14:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#24 File Text:BPX-DXN(4-6DXN) Text:XE13 0967 Exp:BPX04



PCDFsクロマトグラム (1)  
(TeCDFs)

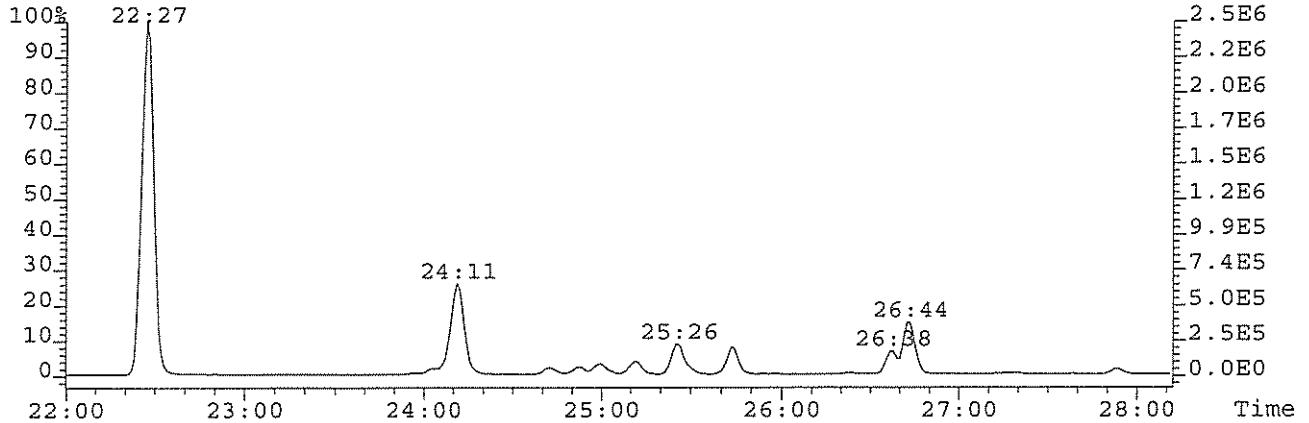
File:130712-2 #1-1578 Acq:13-JUL-2013 10:14:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#24 File Text:BPX-DXN(4-6DXN) Text:XE13 0967 Exp:BPX04  
319.8965 S:24 SMO(1,3)



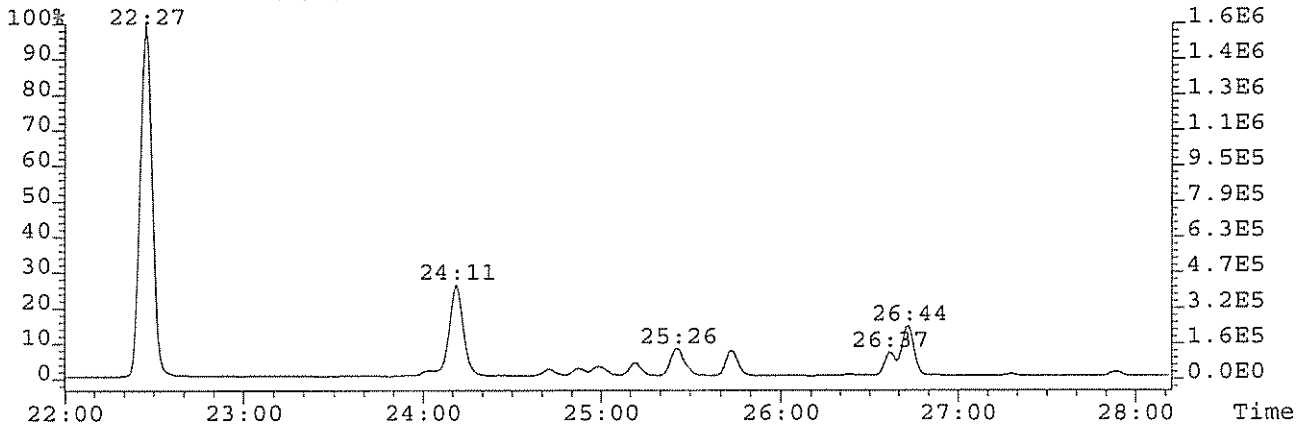
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130712-2 #1-1578 Acq:13-JUL-2013 10:14:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#24 File Text:BPX-DXN(4-6DXN) Text:XE13 0967 Exp:BPX04

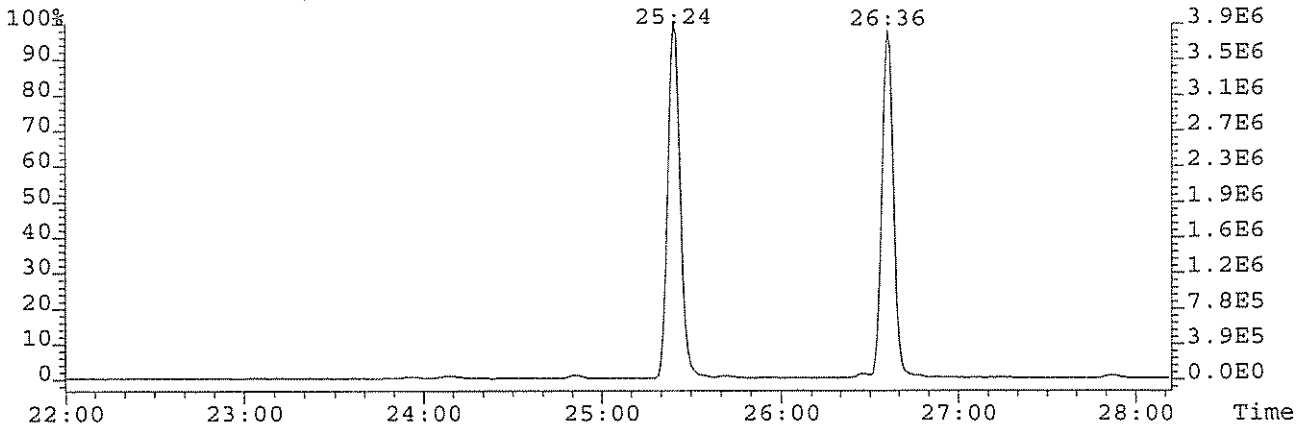
339.8597 S:24 SMO(1,3)



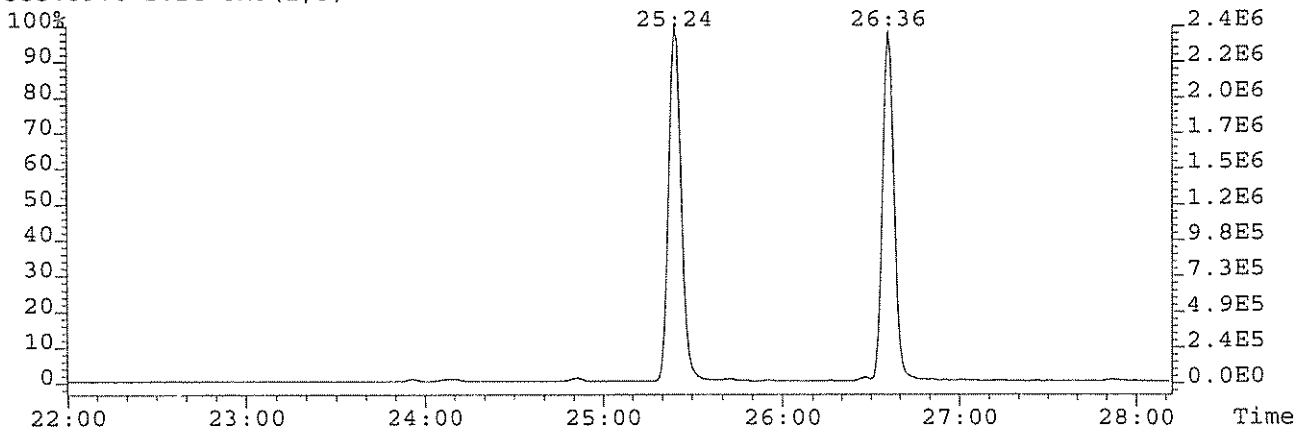
341.8568 S:24 SMO(1,3)



351.9000 S:24 SMO(1,3)



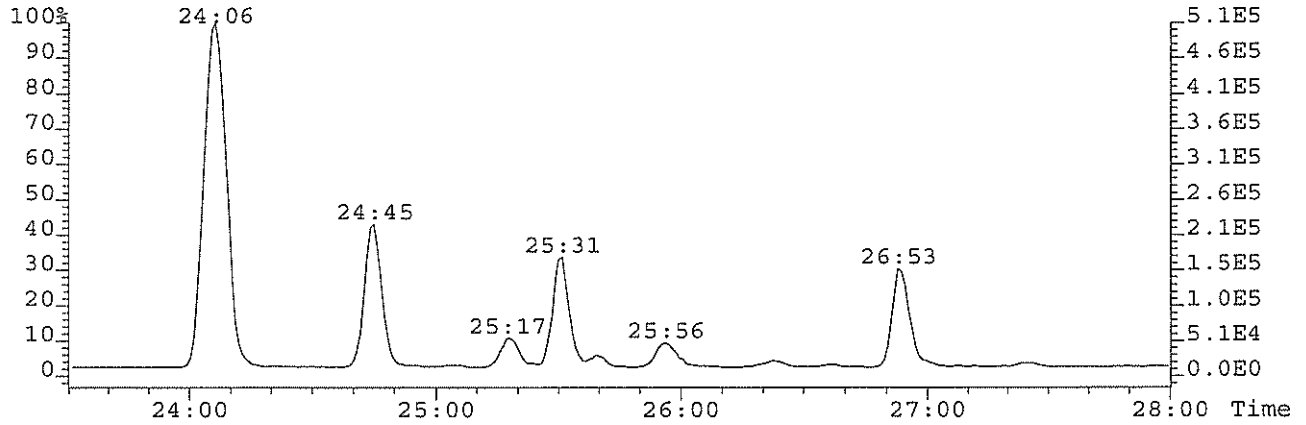
353.8970 S:24 SMO(1,3)



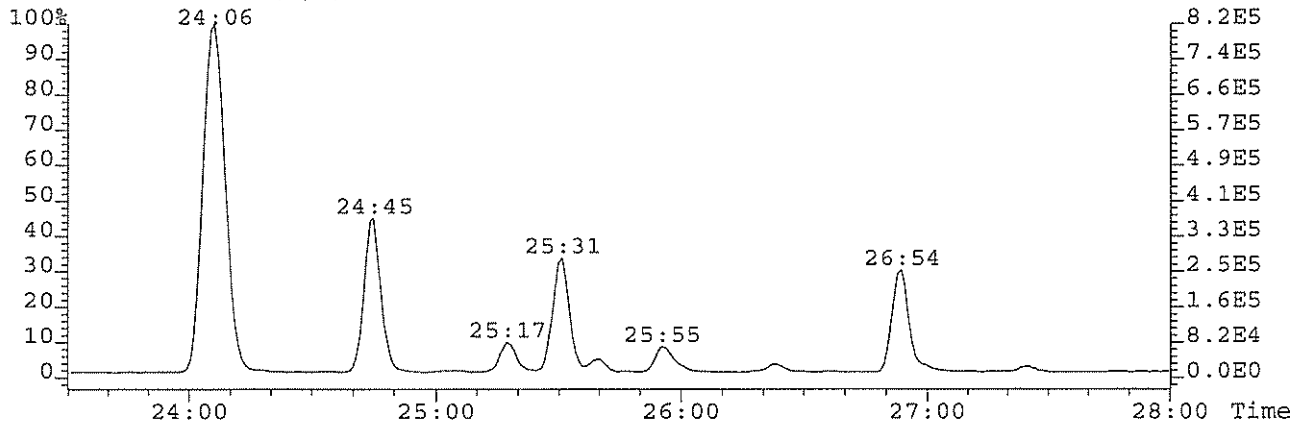
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 10:14:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#24 File Text:BPX-DXN(4-6DXN) Text:XE13 0967 Exp:BPX04

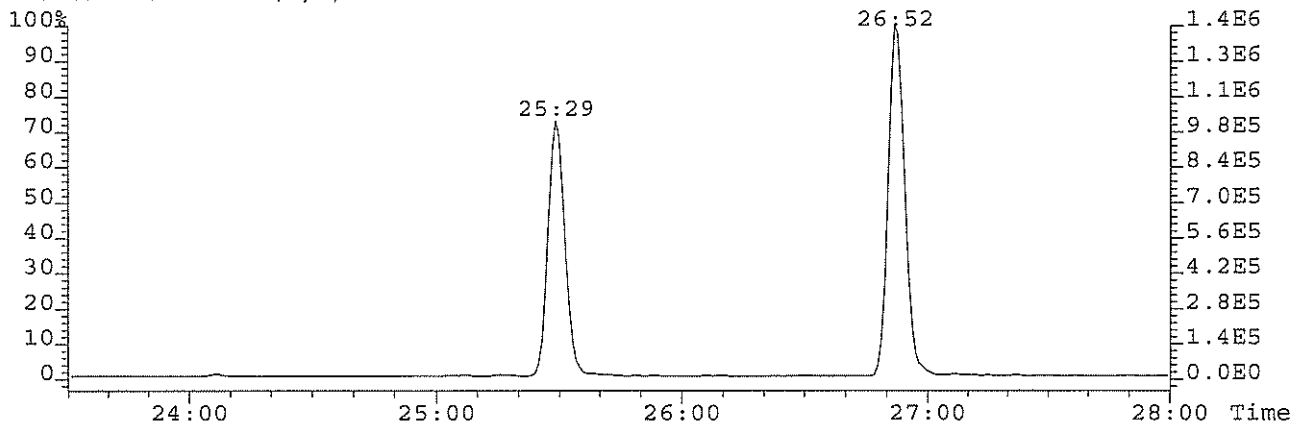
353.8576 S:24 SMO(1,3)



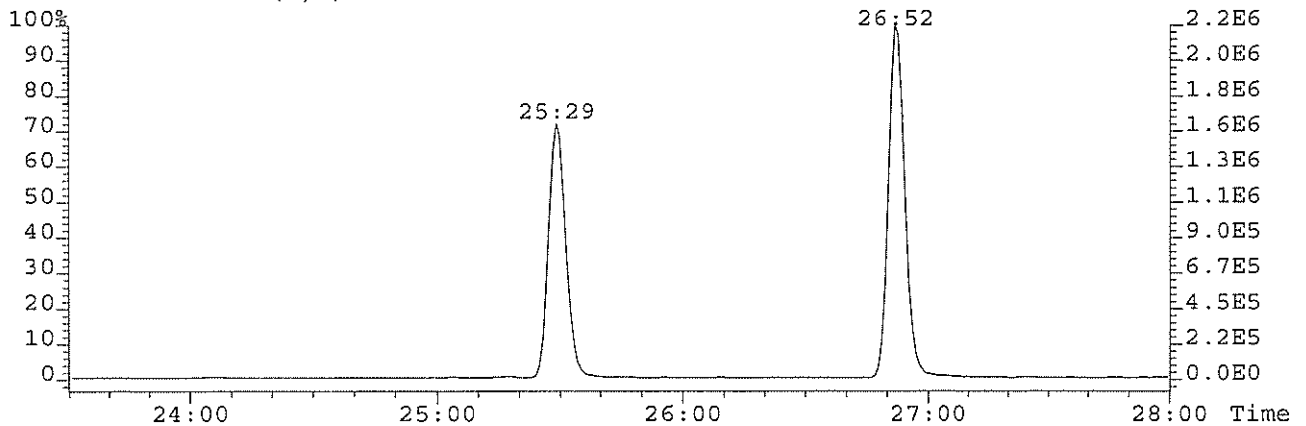
355.8546 S:24 SMO(1,3)



365.8978 S:24 SMO(1,3)



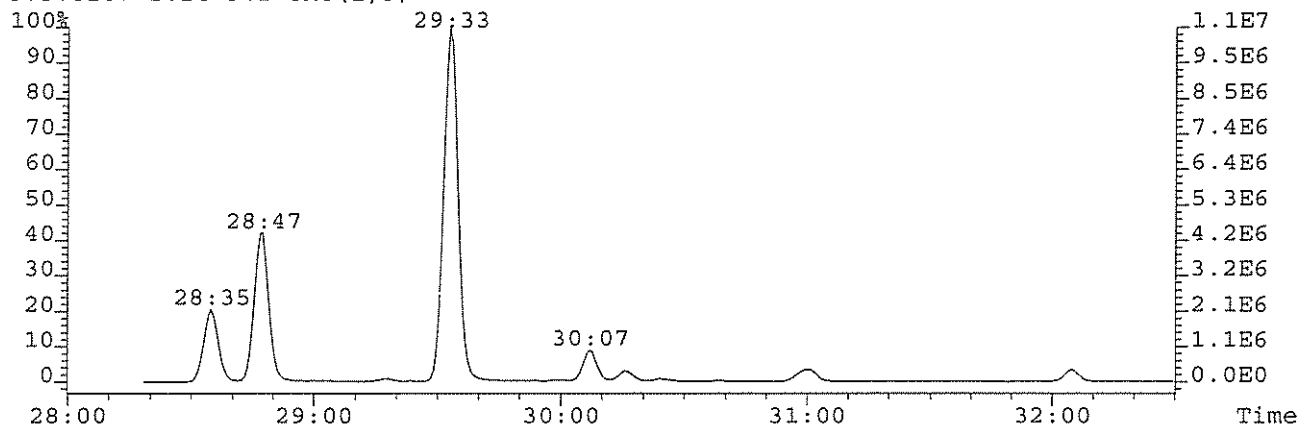
367.8949 S:24 SMO(1,3)



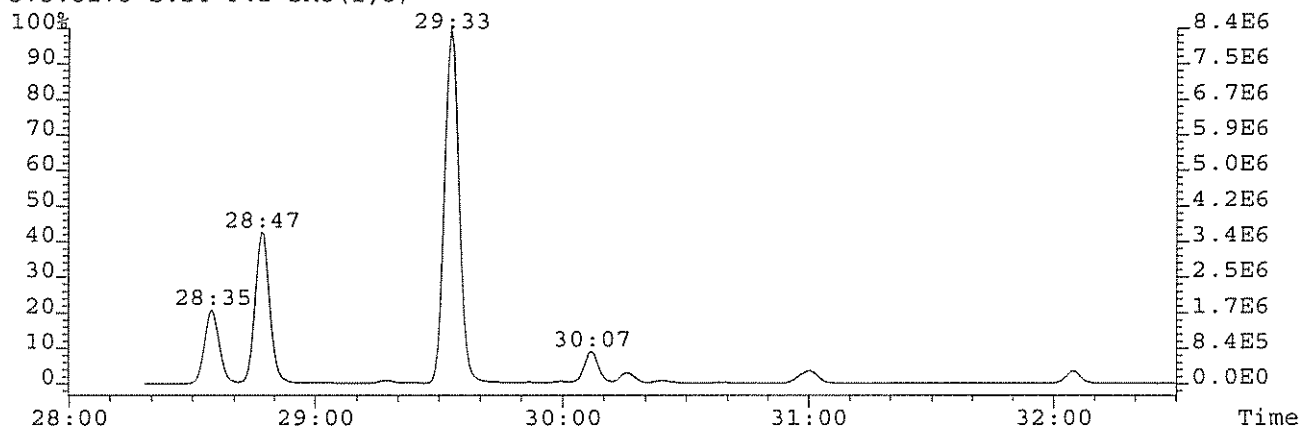
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130712-2 #1-1117 Acq:13-JUL-2013 10:14:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#24 File Text:BPX-DXN(4-6DXN) Text:XE13 0967 Exp:BPX04

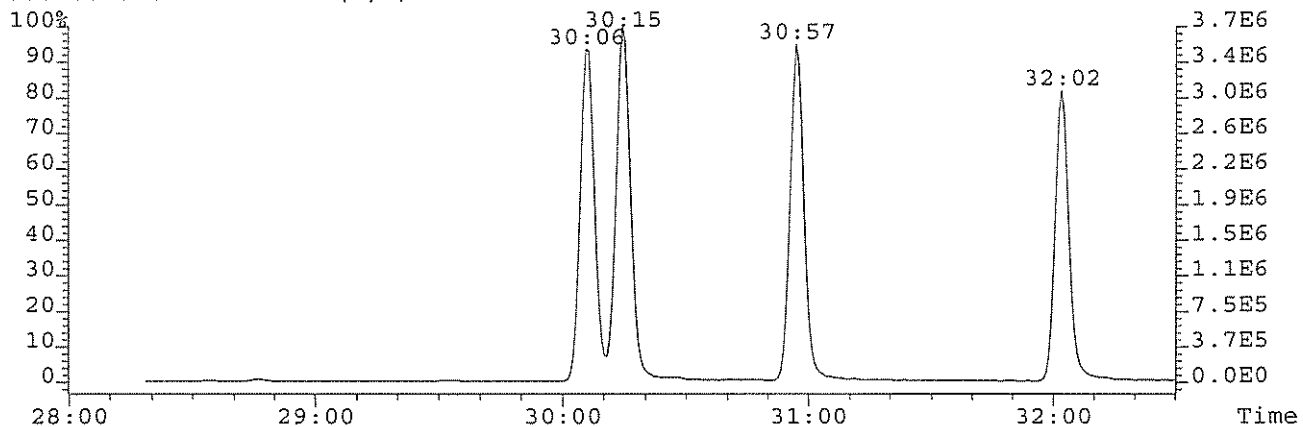
373.8207 S:24 F:2 SMO(1,3)



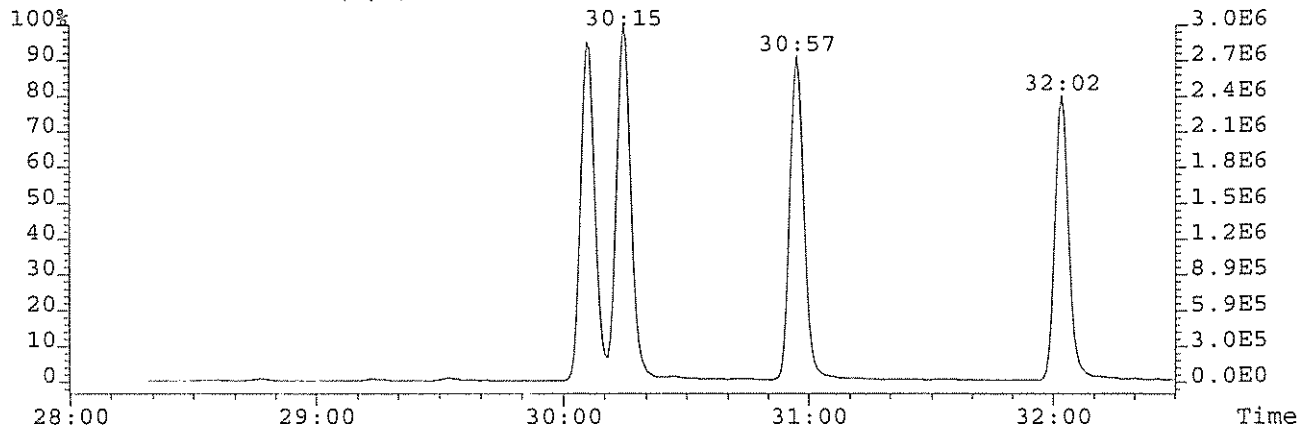
375.8178 S:24 F:2 SMO(1,3)



385.8610 S:24 F:2 SMO(1,3)



387.8580 S:24 F:2 SMO(1,3)

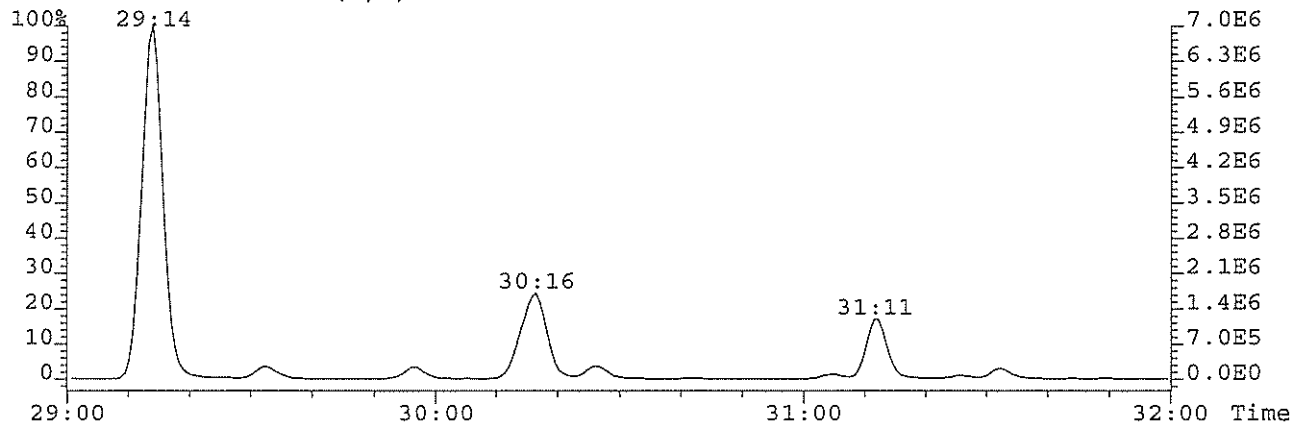


PCDFsクロマトグラム (5)  
(HxCDFs)

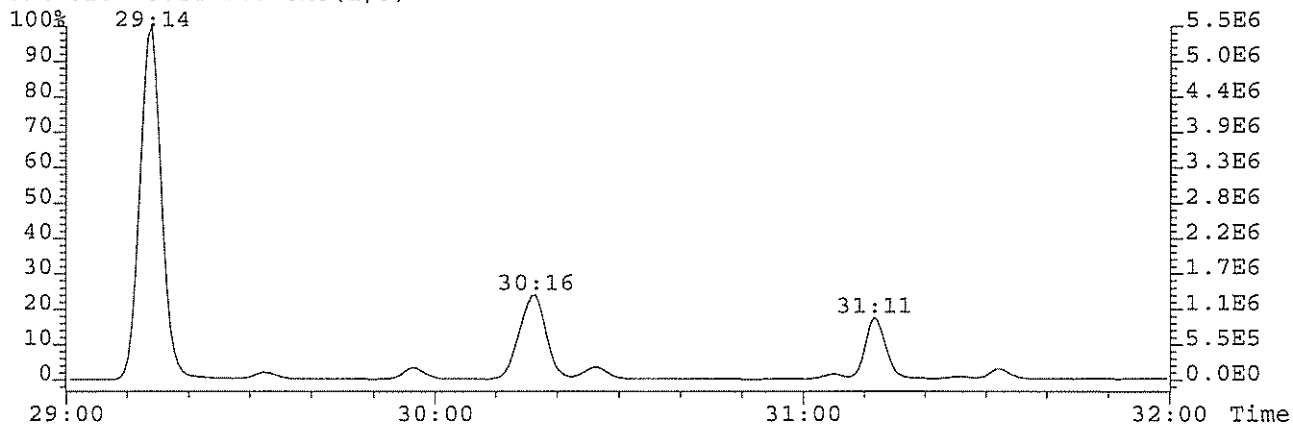


File:130712-2 #1-1117 Acq:13-JUL-2013 10:14:52 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#24 File Text:BPX-DXN(4-6DXN) Text:XE13 0967 Exp:BPX04

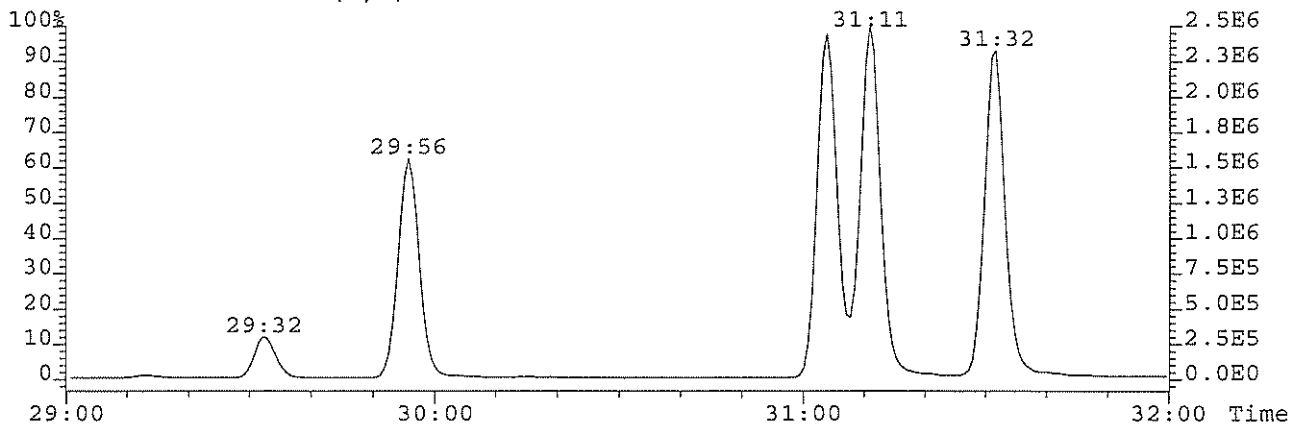
389.8156 S:24 F:2 SMO(1,3)



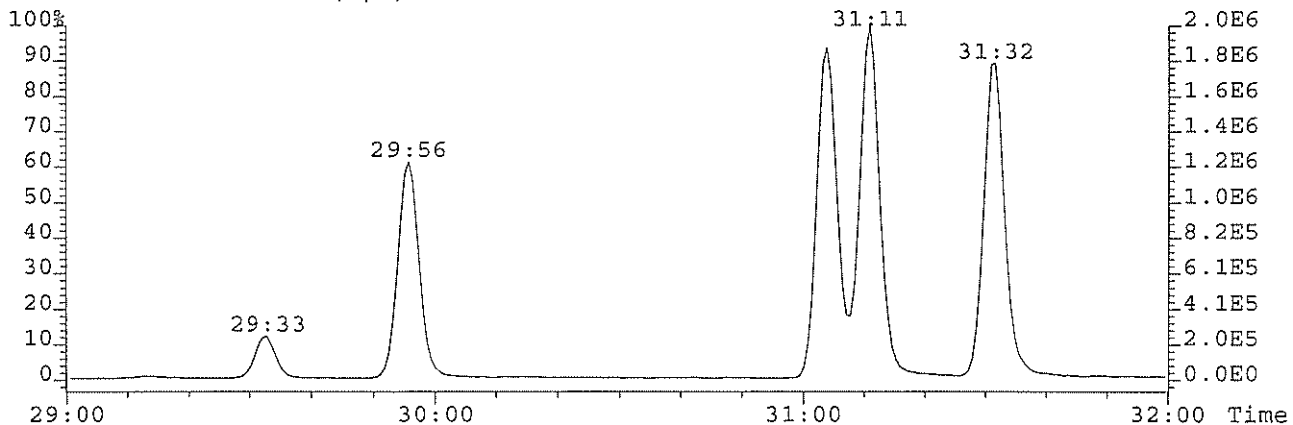
391.8127 S:24 F:2 SMO(1,3)



401.8559 S:24 F:2 SMO(1,3)



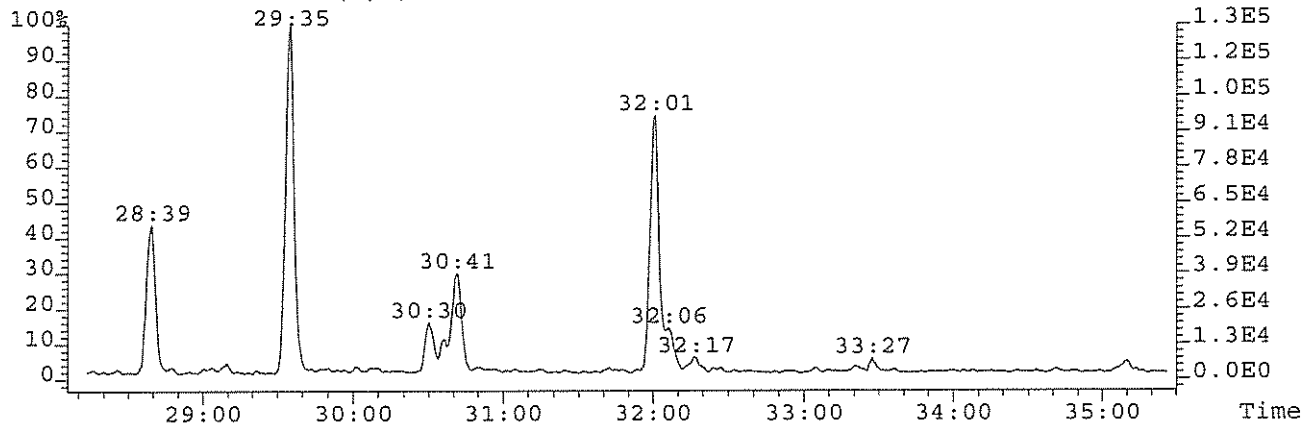
403.8530 S:24 F:2 SMO(1,3)



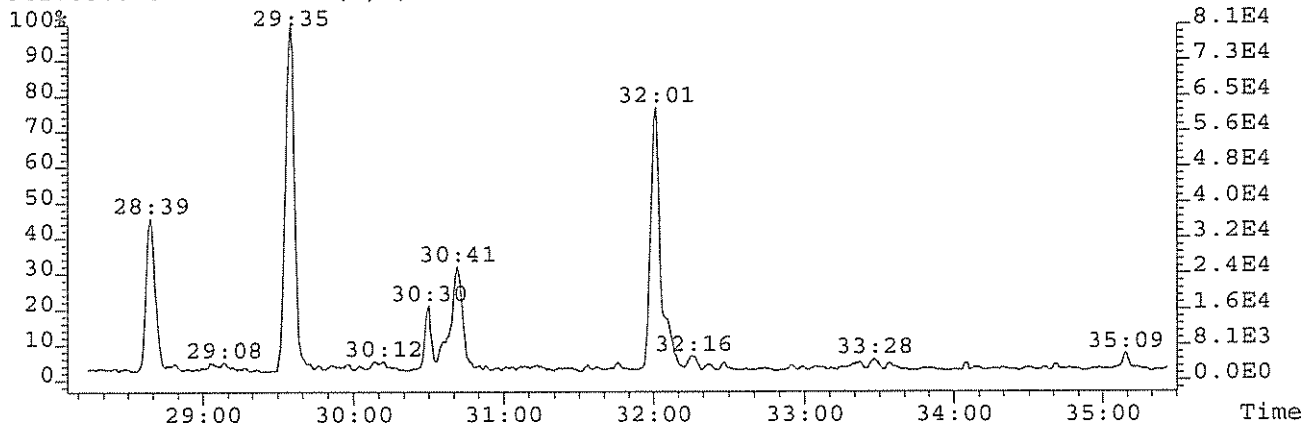
PCDDsクロマトグラム (6)  
(HxCDDs)

File:130713 #1-648 Acq:14-JUL-2013 04:44:29 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(5-8,nP) Text:XE13 0967 3 Exp:RH-PD22

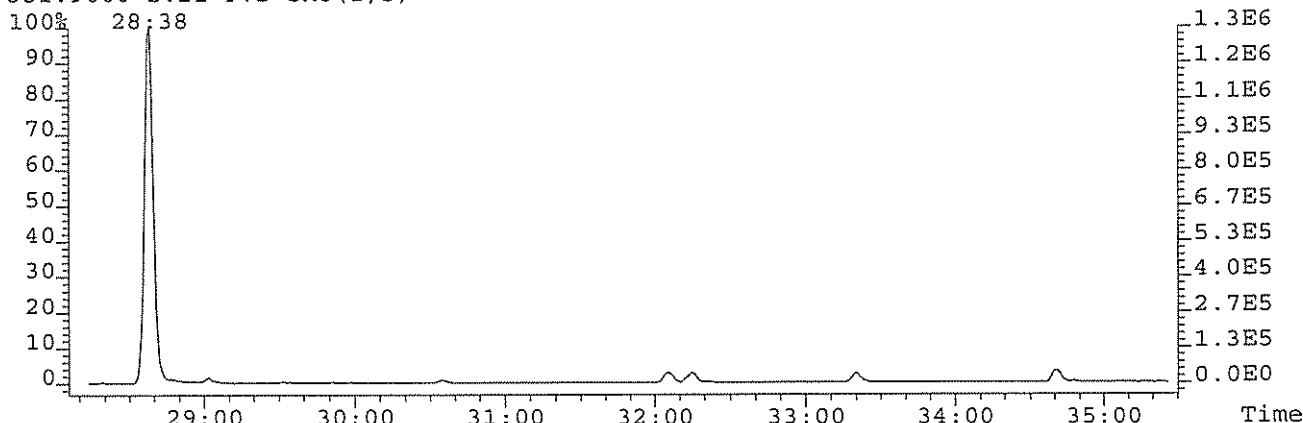
339.8597 S:21 F:2 SMO(1,3)



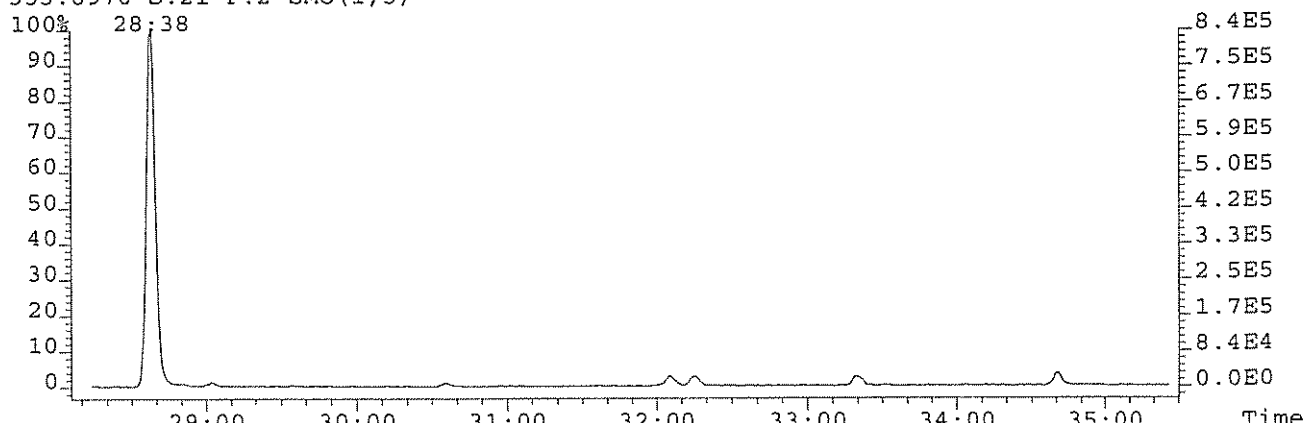
341.8568 S:21 F:2 SMO(1,3)



351.9000 S:21 F:2 SMO(1,3)

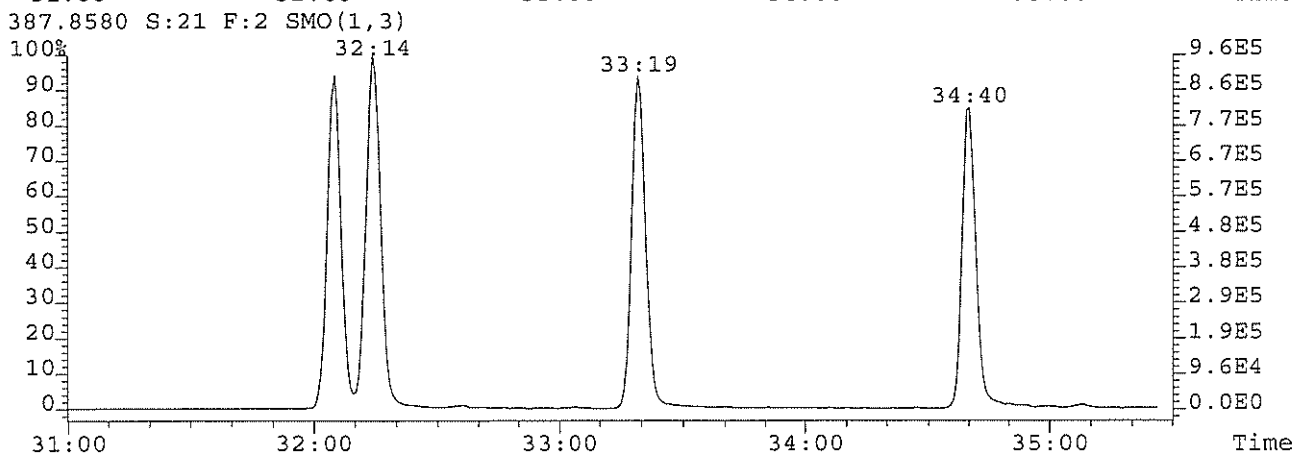
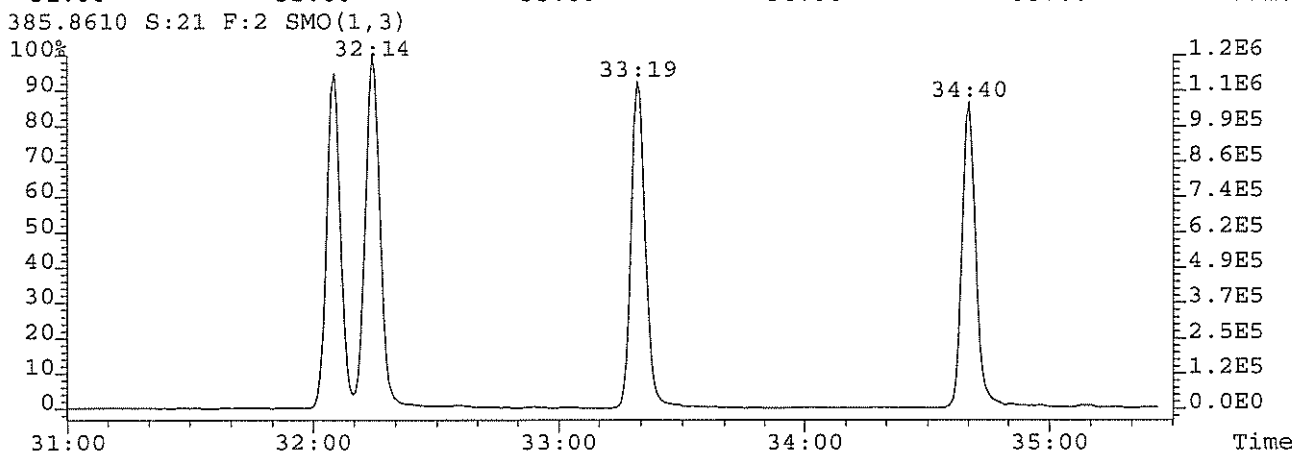
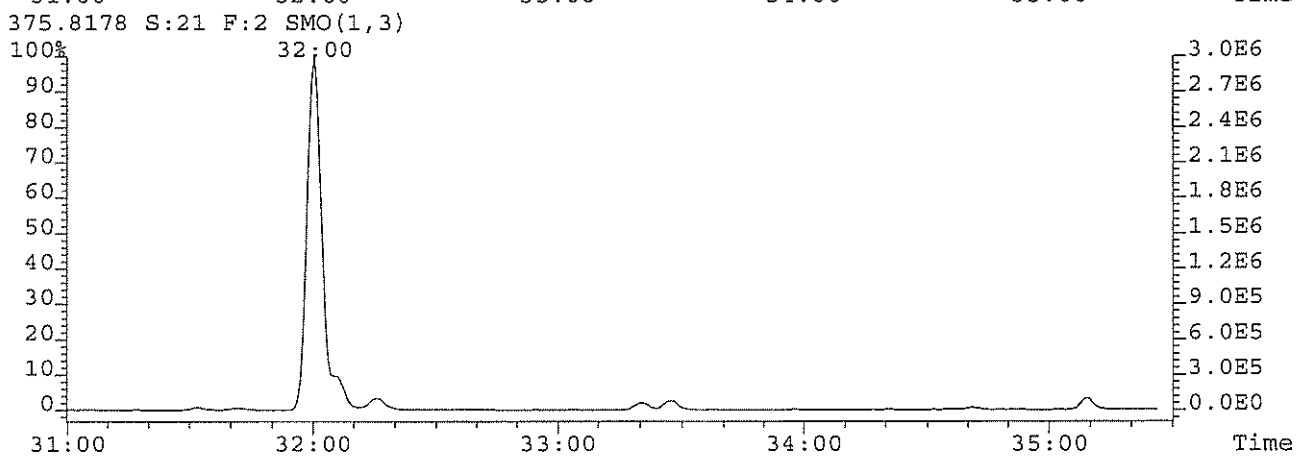
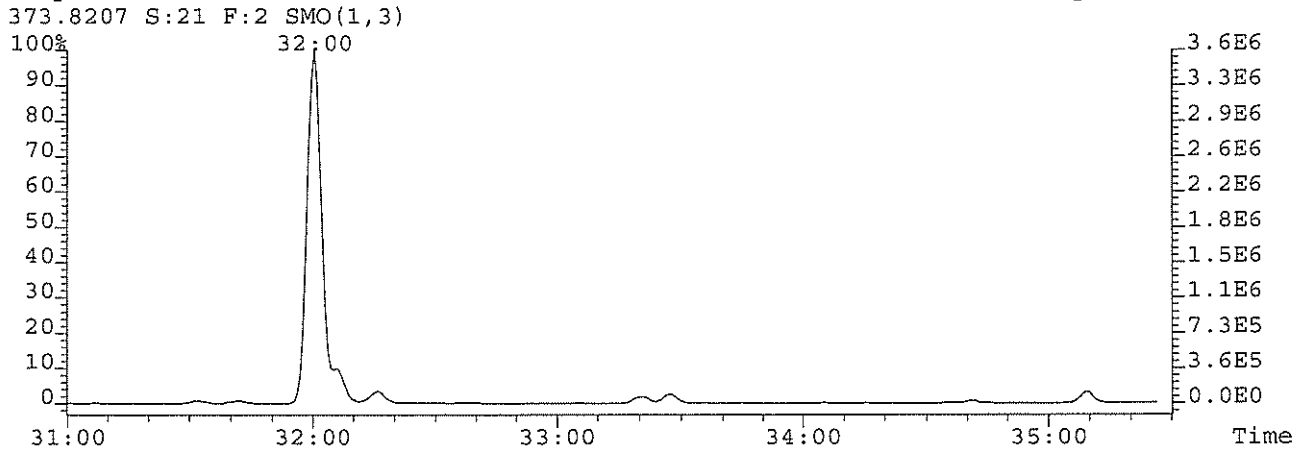


353.8970 S:21 F:2 SMO(1,3)



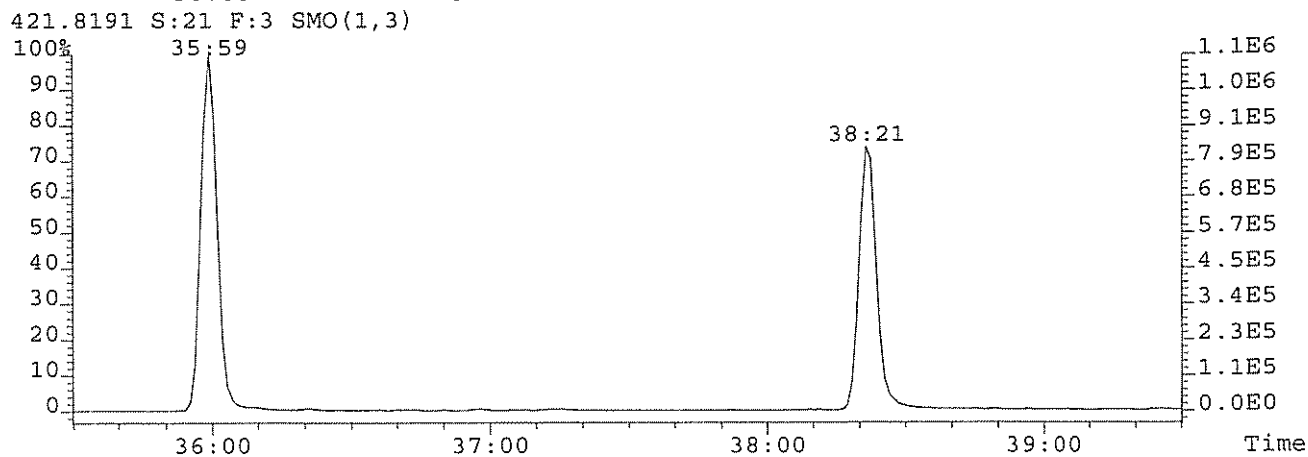
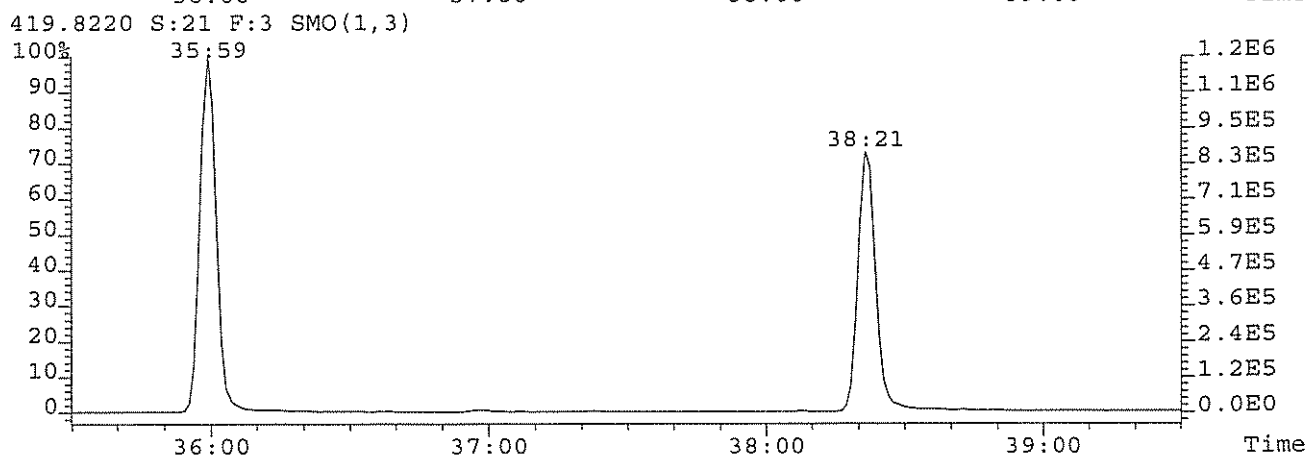
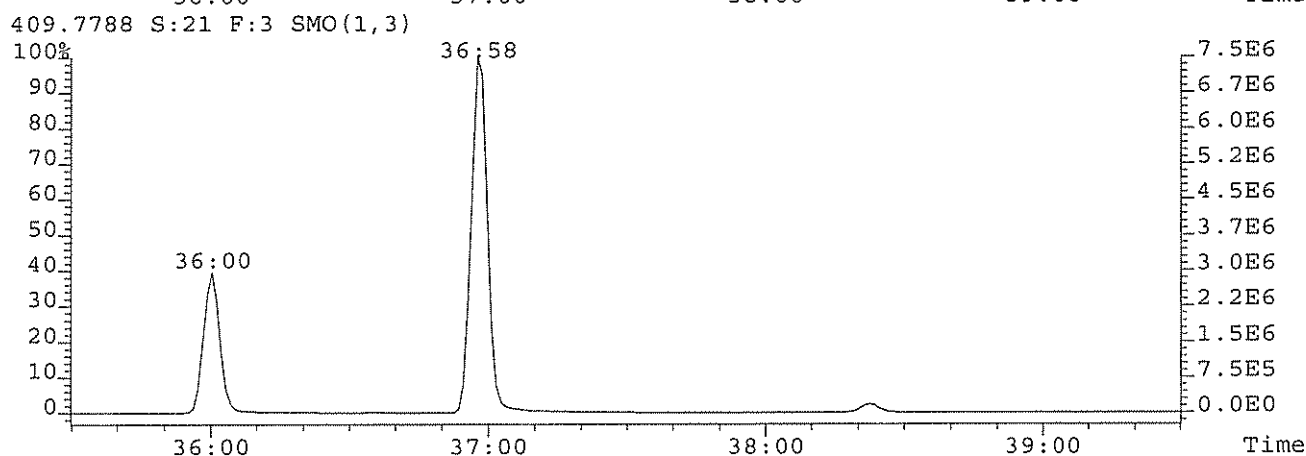
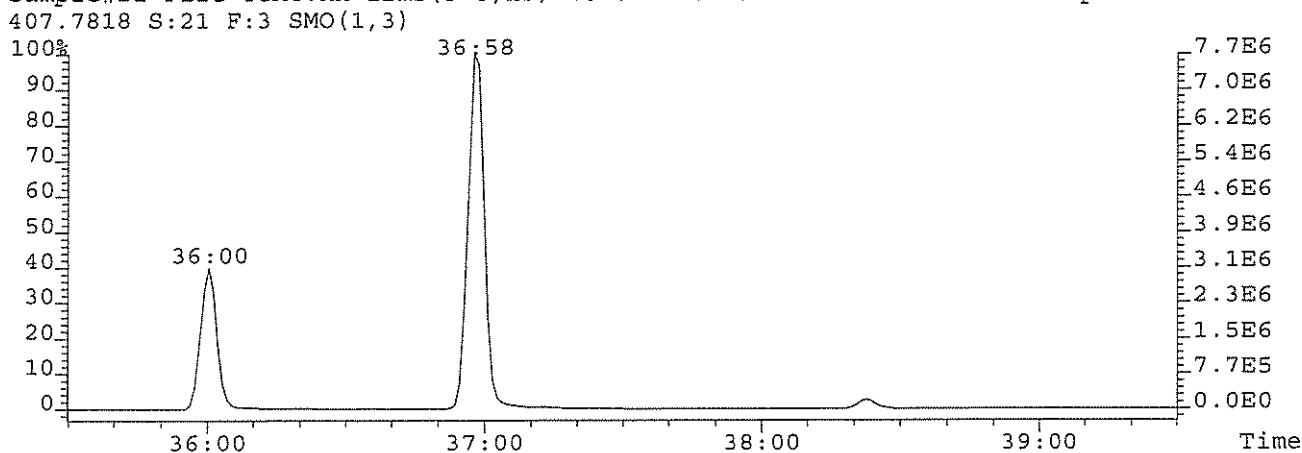
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130713 #1-648 Acq:14-JUL-2013 04:44:29 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(5-8,nP) Text:XE13 0967 3 Exp:RH-PD22



HxCDFsクロマトグラム (8)  
(123789-HxCDF)

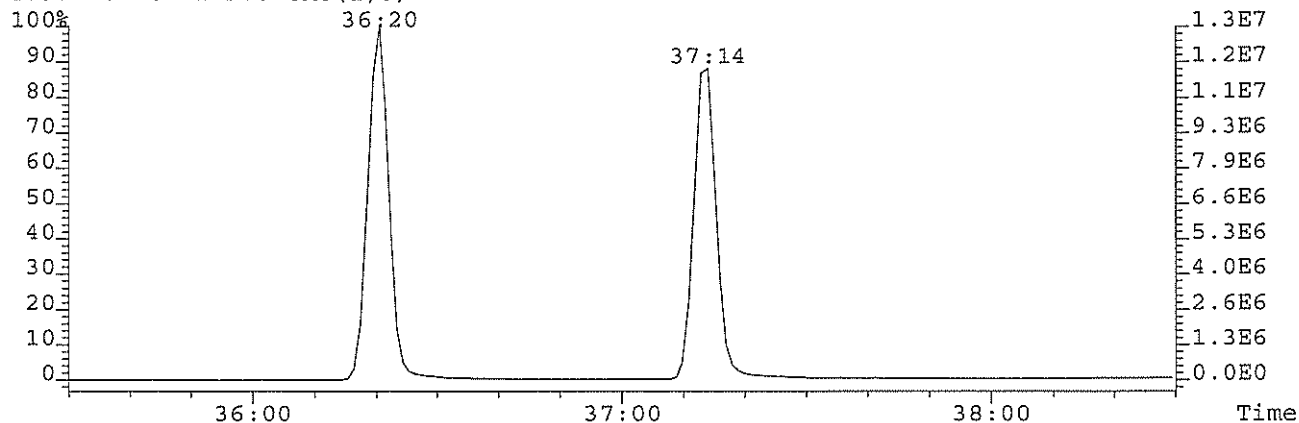
File:130713 #1-562 Acq:14-JUL-2013 04:44:29 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(5-8,nP) Text:XE13 0967 3 Exp:RH-PD22



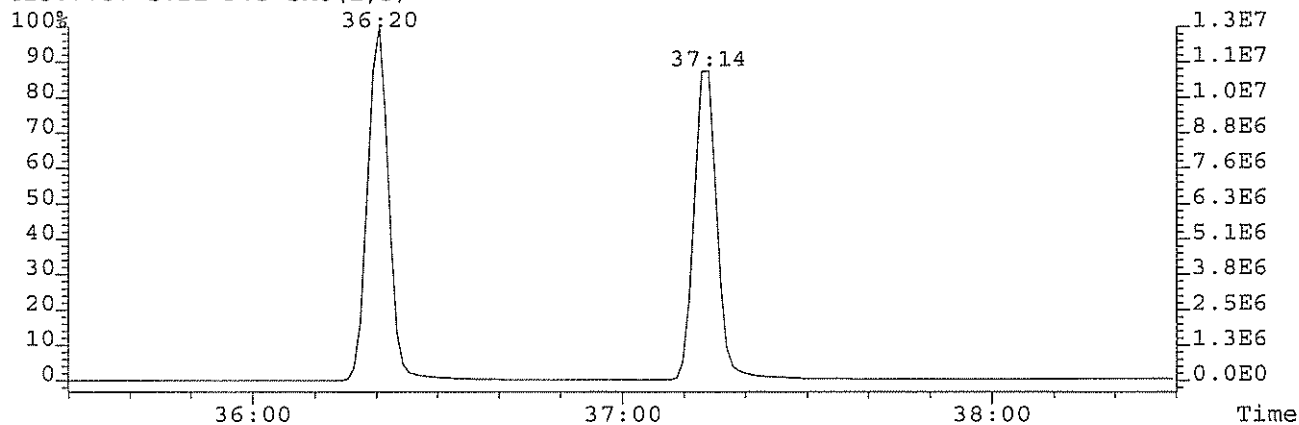
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130713 #1-562 Acq:14-JUL-2013 04:44:29 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(5-8,nP) Text:XE13 0967 3 Exp:RH-PD22

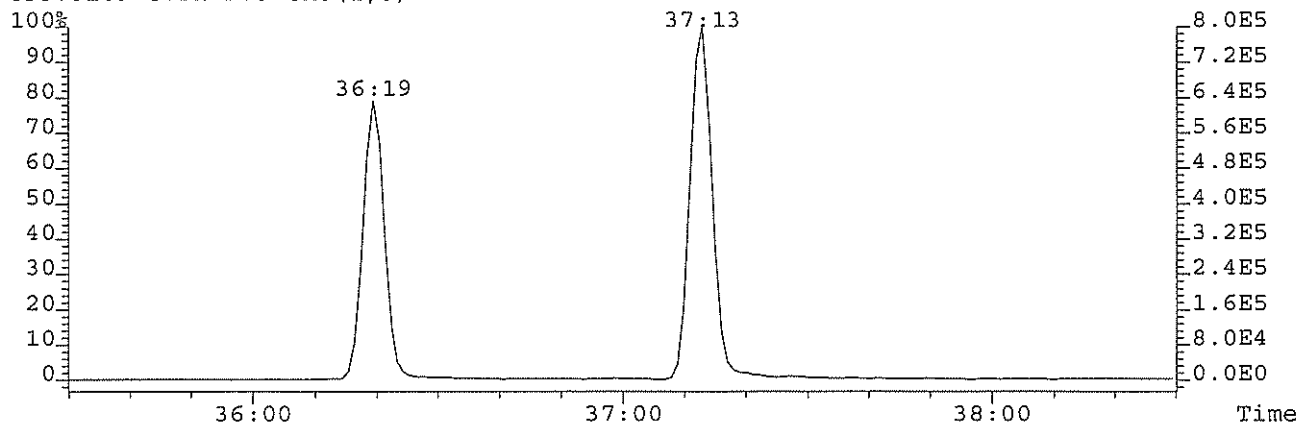
423.7767 S:21 F:3 SMO(1,3)



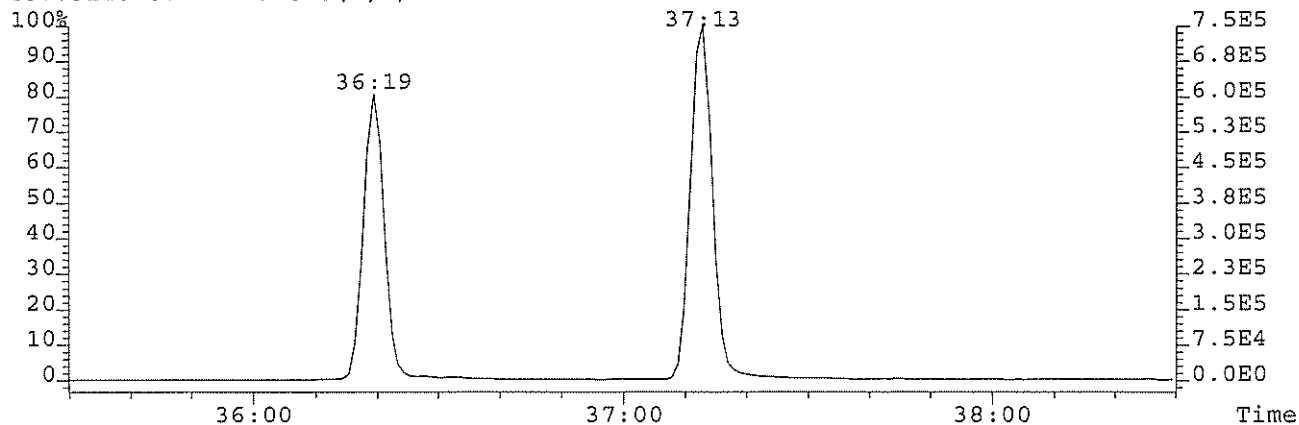
425.7737 S:21 F:3 SMO(1,3)



435.8169 S:21 F:3 SMO(1,3)



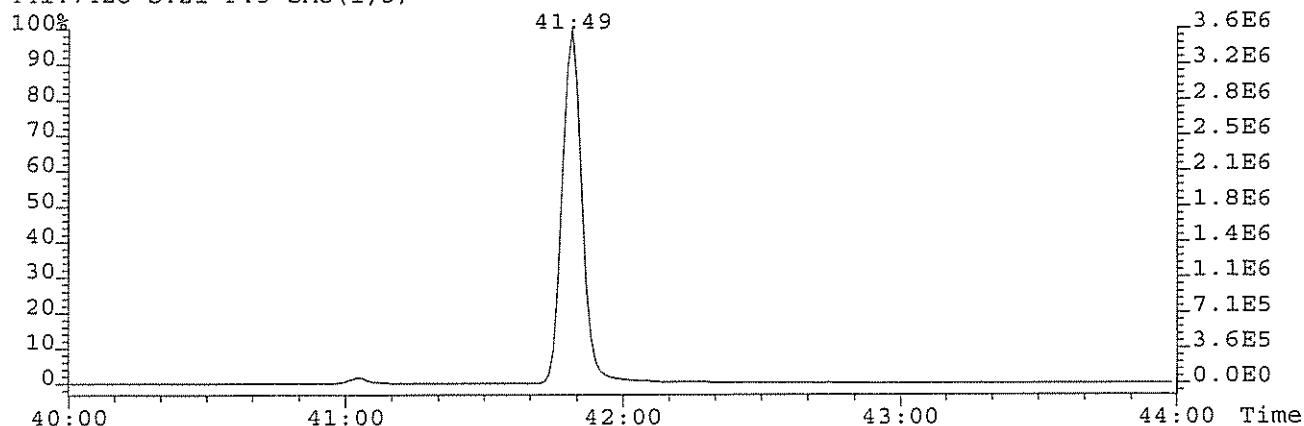
437.8140 S:21 F:3 SMO(1,3)



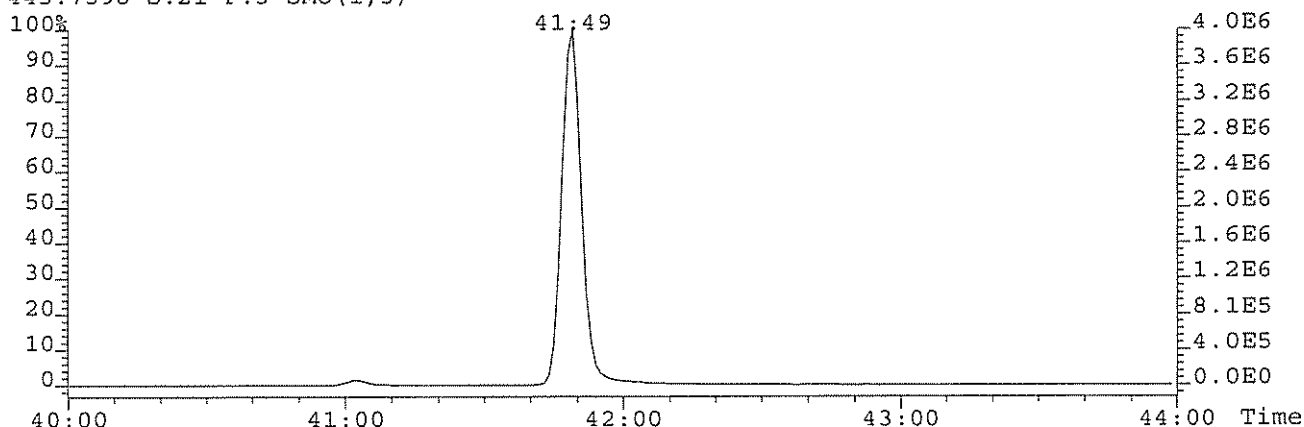
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130713 #1-562 Acq:14-JUL-2013 04:44:29 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(5-8,nP) Text:XE13 0967 3 Exp:RH-PD22

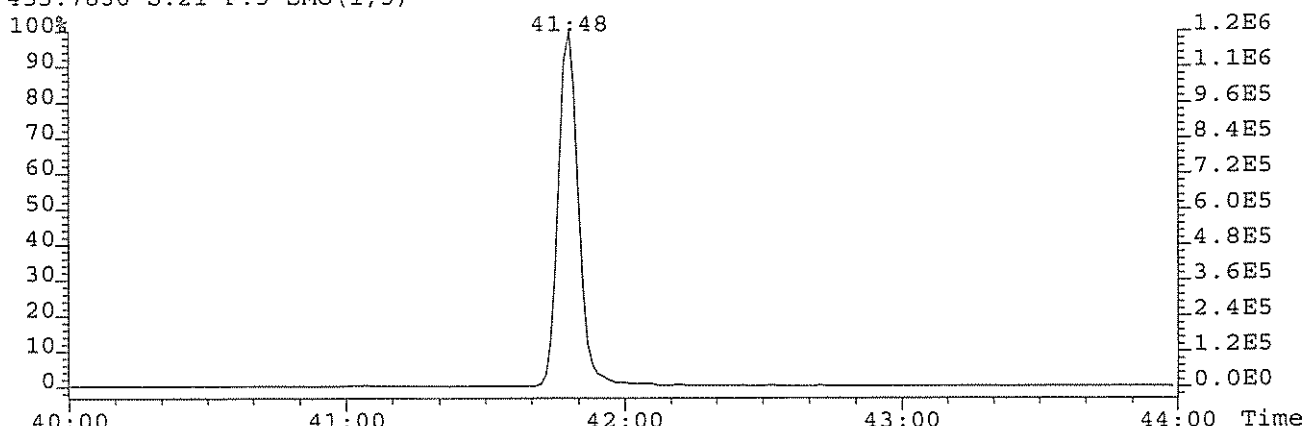
441.7428 S:21 F:3 SMO(1,3)



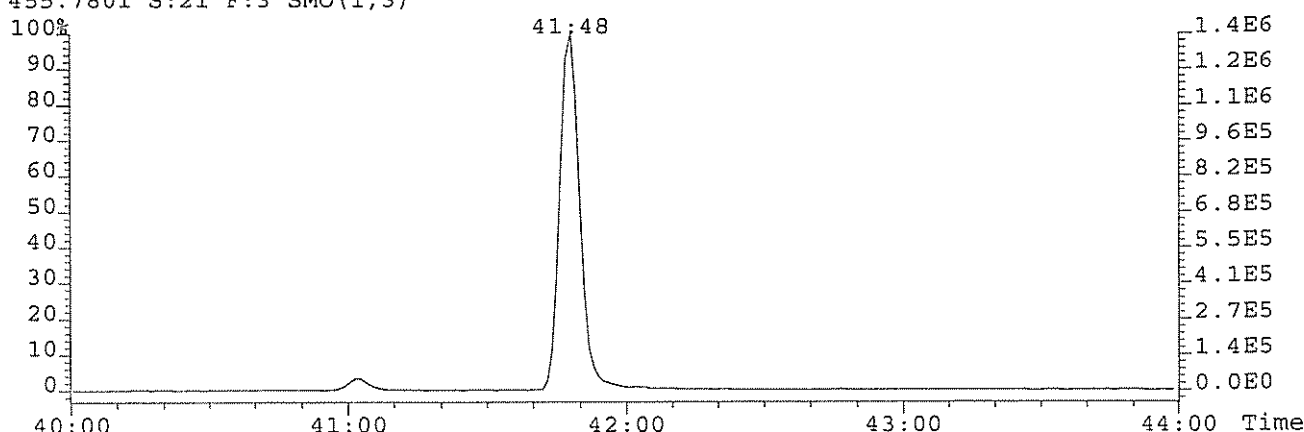
443.7398 S:21 F:3 SMO(1,3)



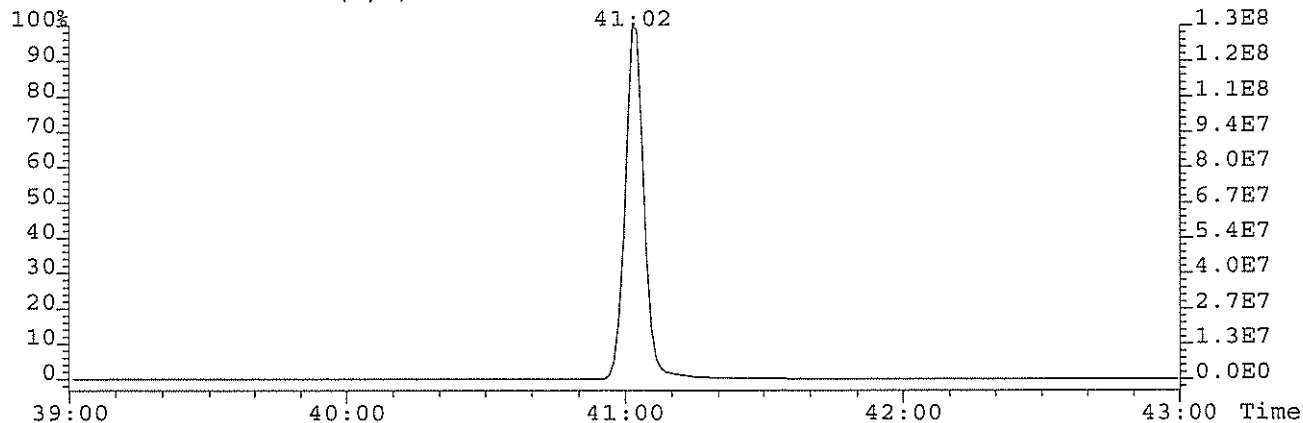
453.7830 S:21 F:3 SMO(1,3)



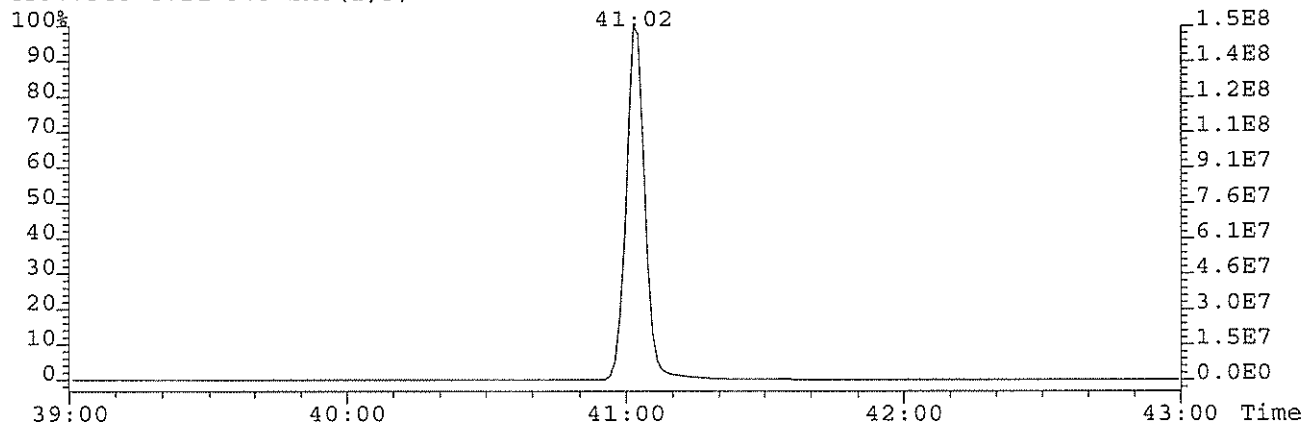
455.7801 S:21 F:3 SMO(1,3)



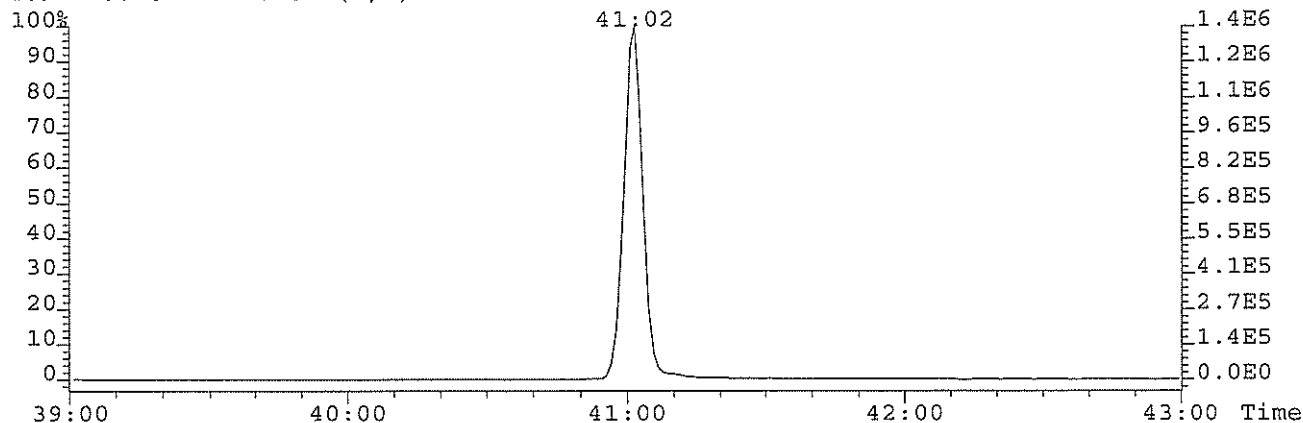
File:130713 #1-562 Acq:14-JUL-2013 04:44:29 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(5-8,nP) Text:XE13 0967 3 Exp:RH-PD22  
457.7377 S:21 F:3 SMO(1,3)



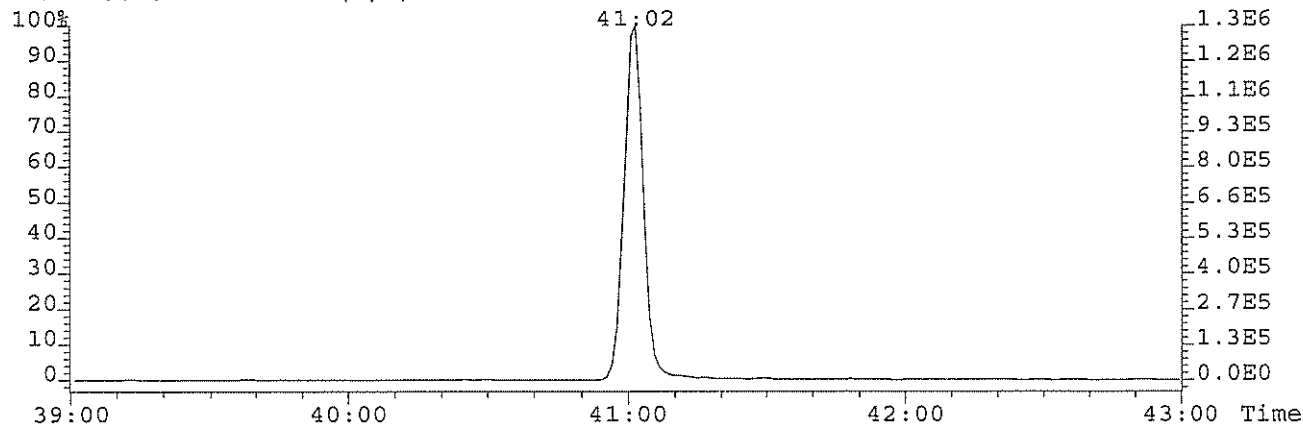
459.7348 S:21 F:3 SMO(1,3)



469.7780 S:21 F:3 SMO(1,3)

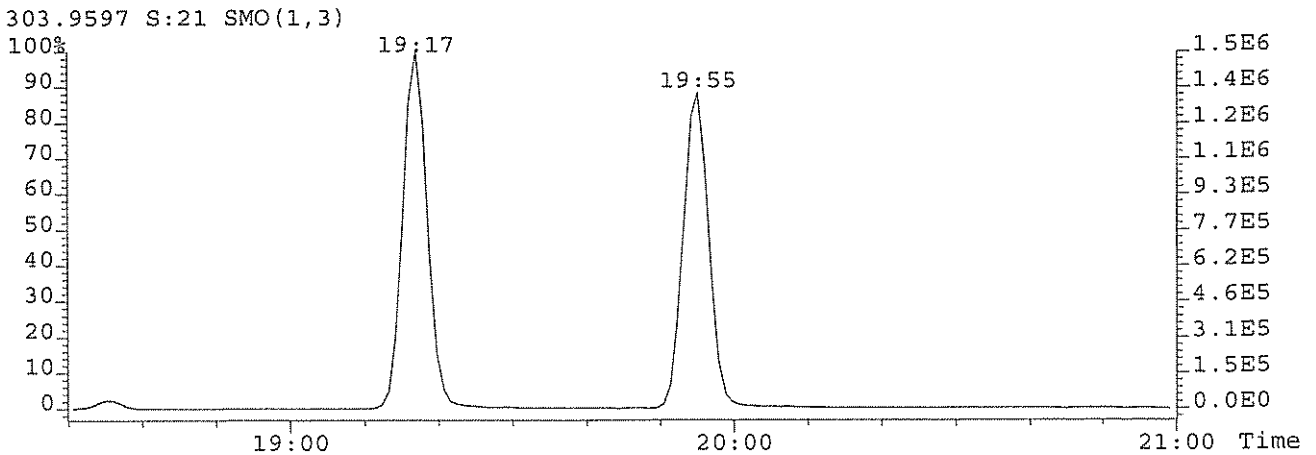
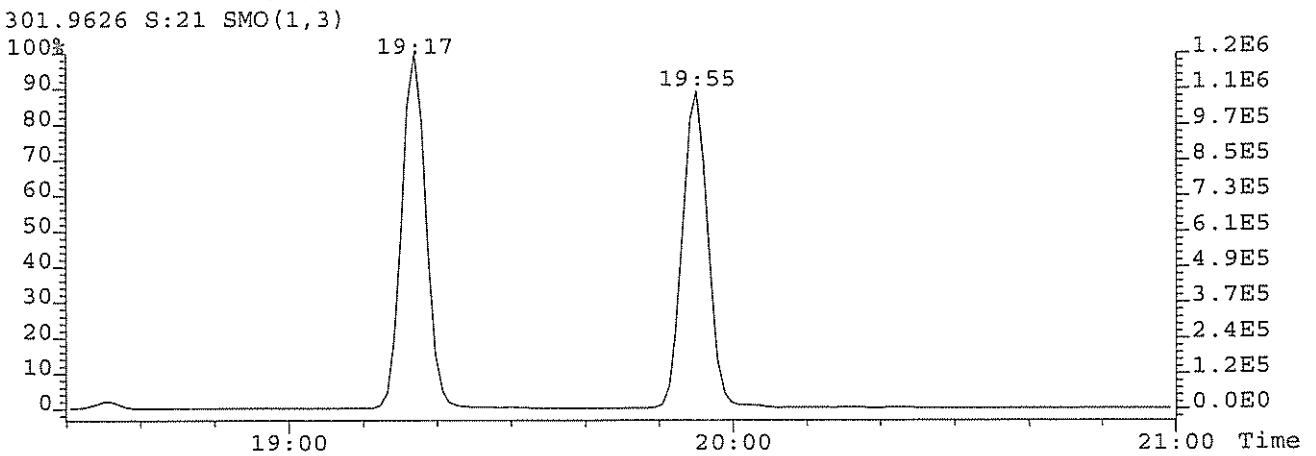
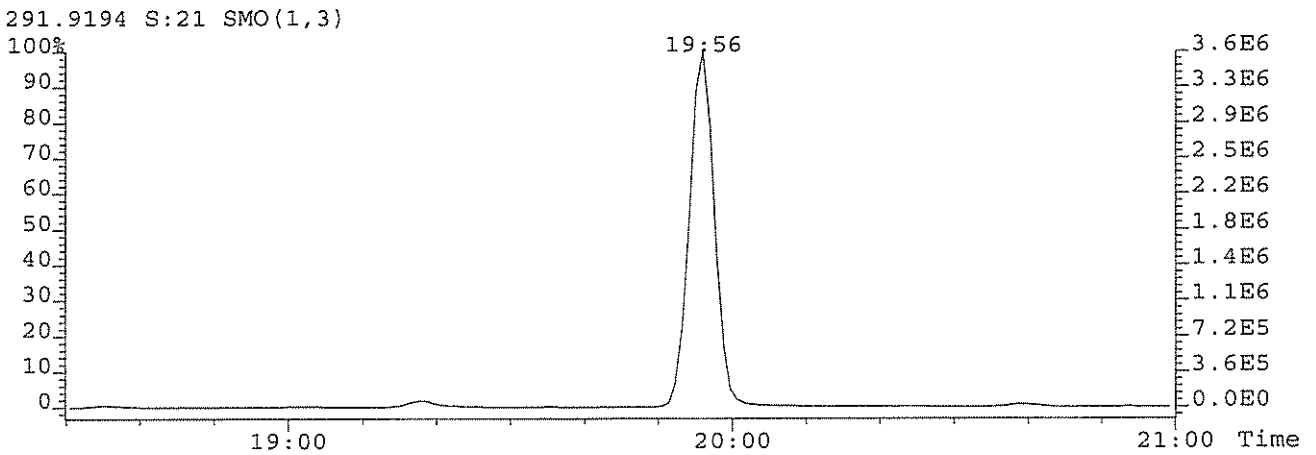
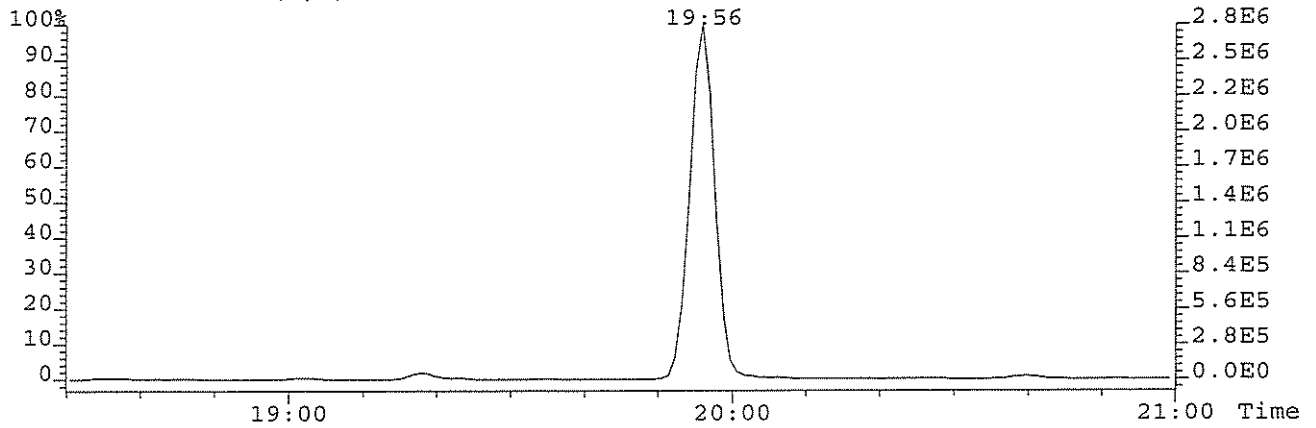


471.7750 S:21 F:3 SMO(1,3)



PCDDsクロマトグラム (12)  
(OCDD)

File:130713 #1-1430 Acq:14-JUL-2013 04:44:29 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(5-8,nP) Text:XE13 0967 3 Exp:RH-PD22  
289.9224 S:21 SMO(1,3)

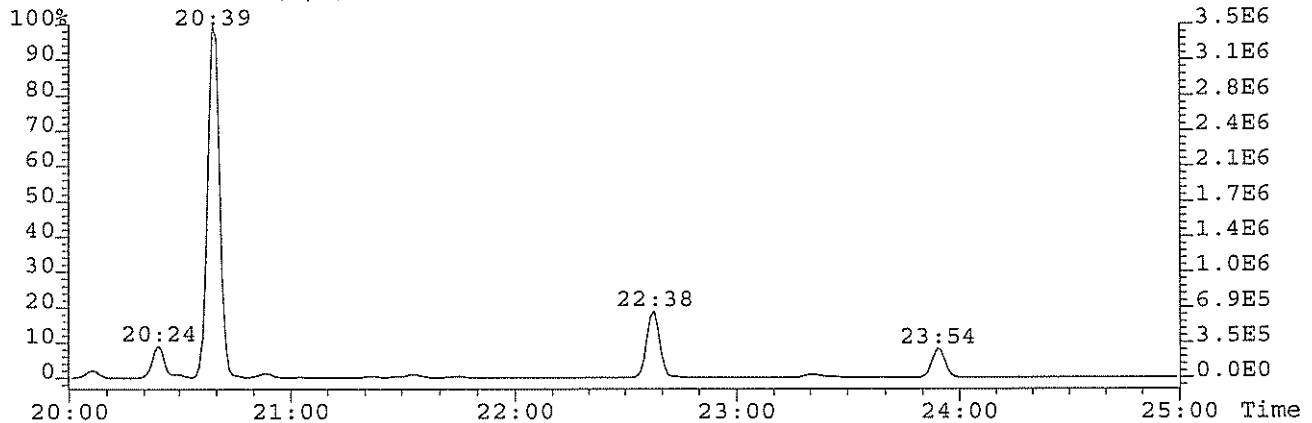


DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

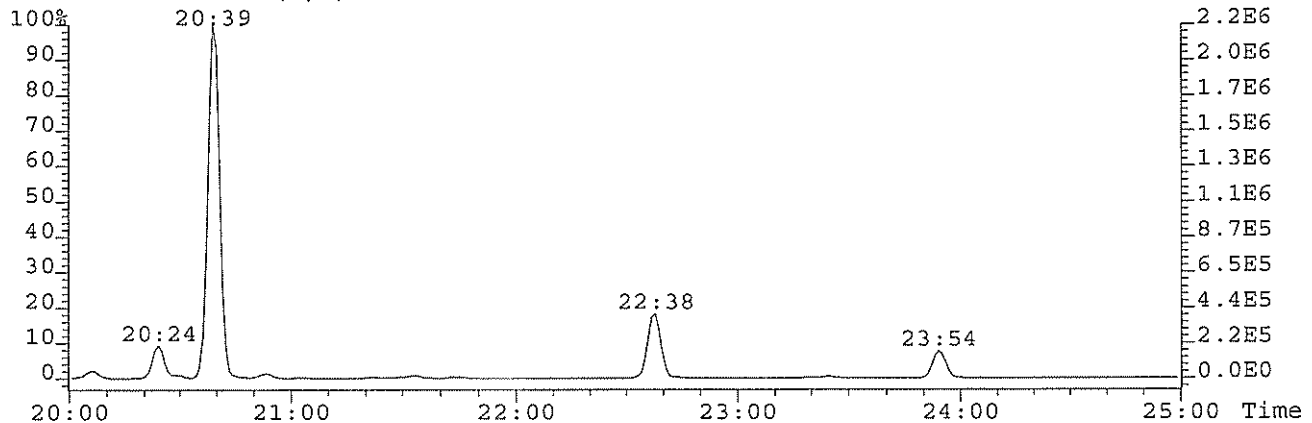


File:130713 #1-1430 Acq:14-JUL-2013 04:44:29 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(5-8,nP) Text:XE13 0967 3 Exp:RH-PD22

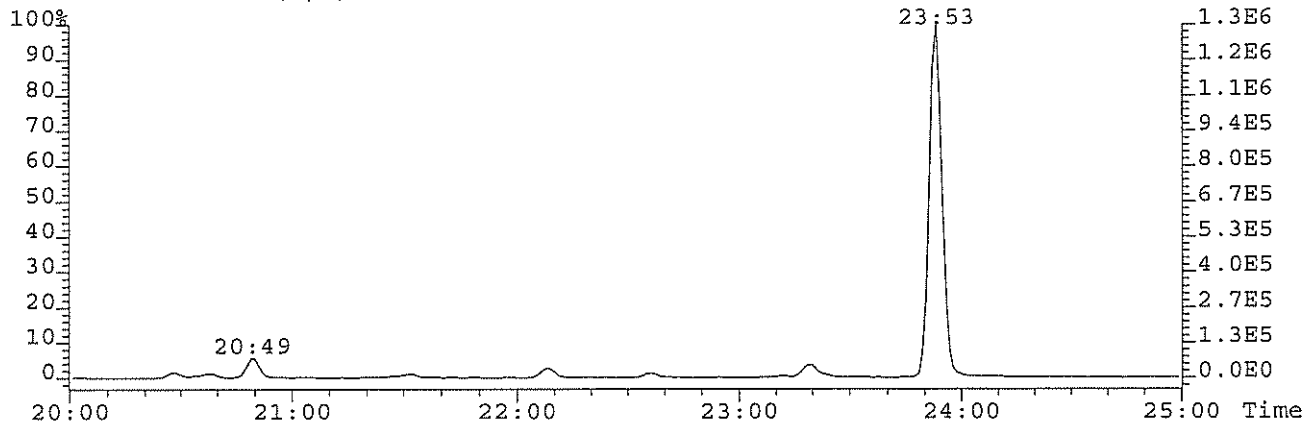
325.8804 S:21 SMO(1,3)



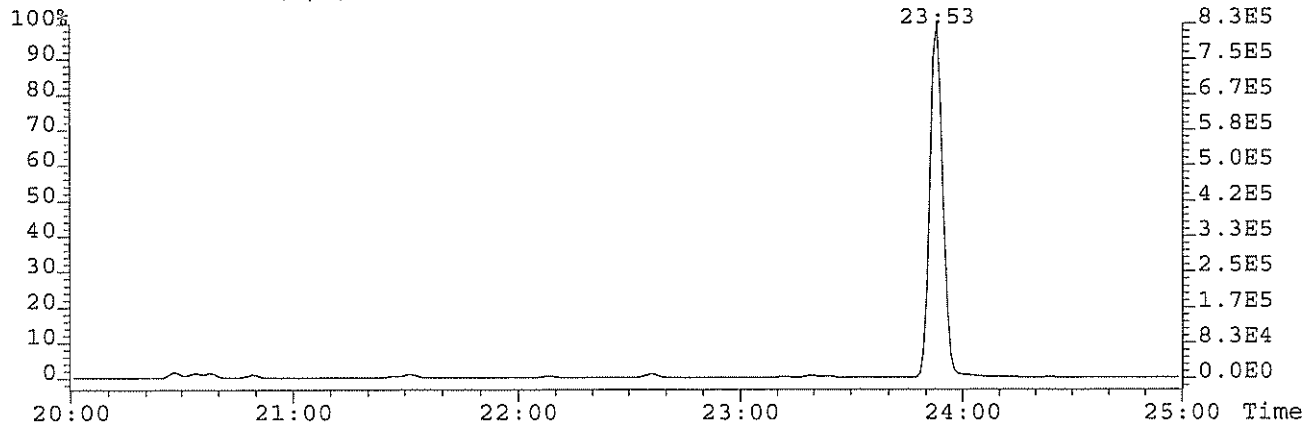
327.8775 S:21 SMO(1,3)



337.9207 S:21 SMO(1,3)

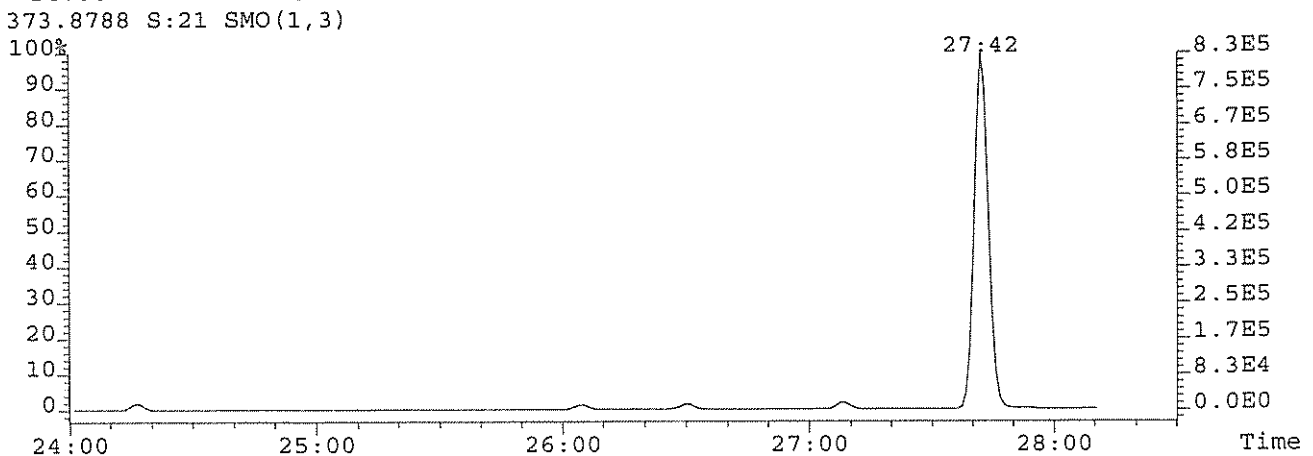
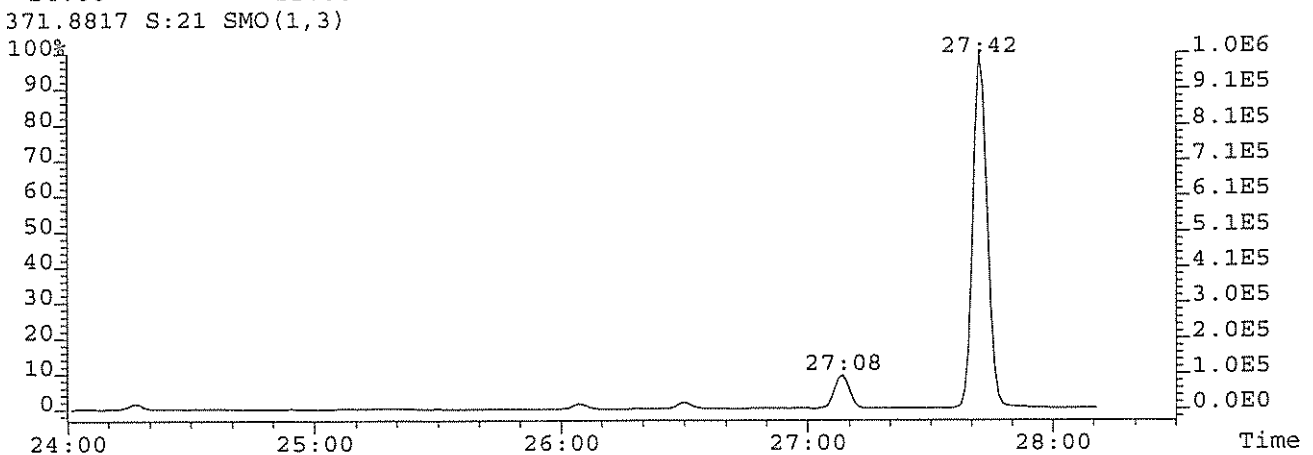
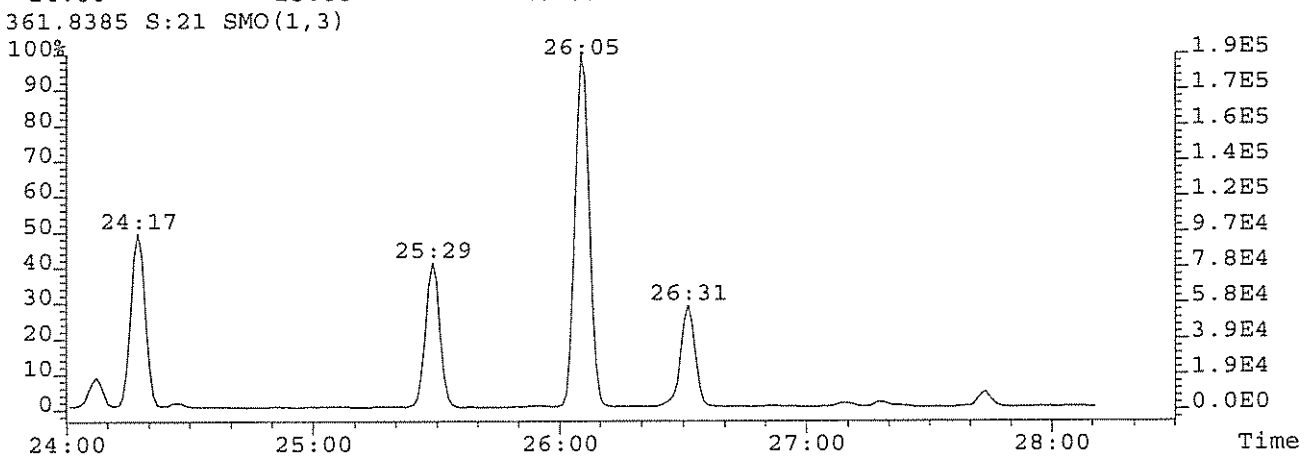
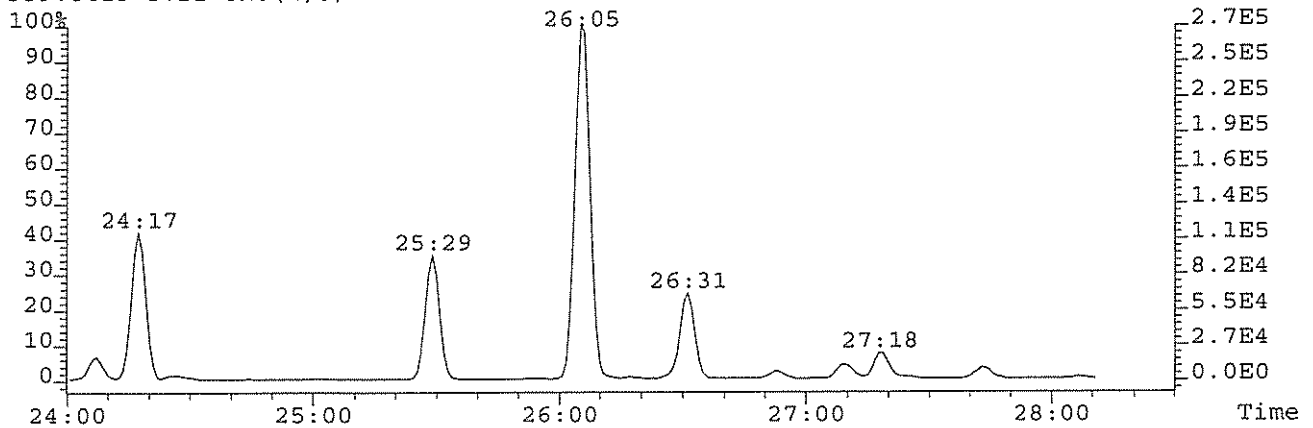


339.9178 S:21 SMO(1,3)



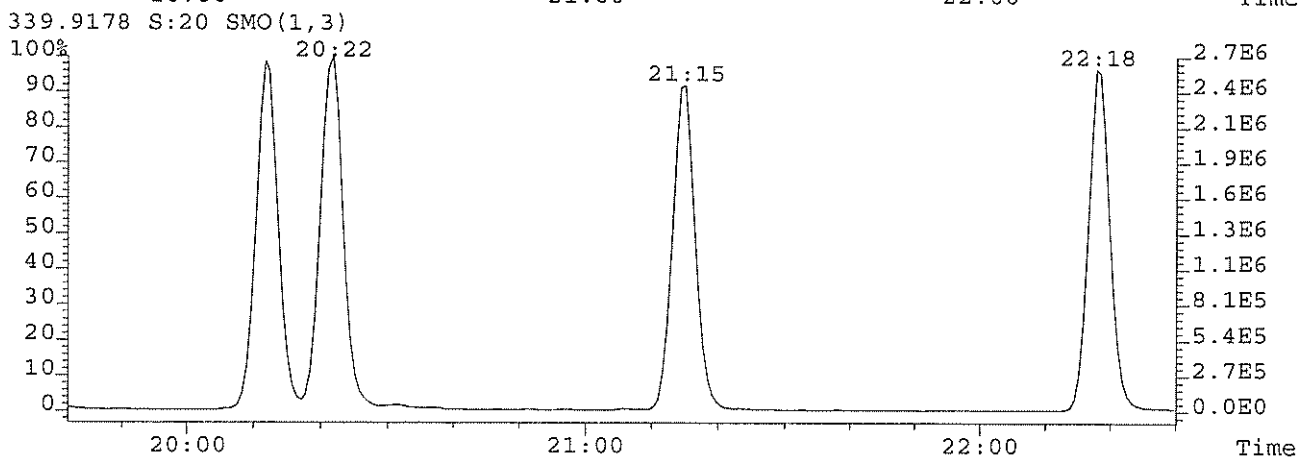
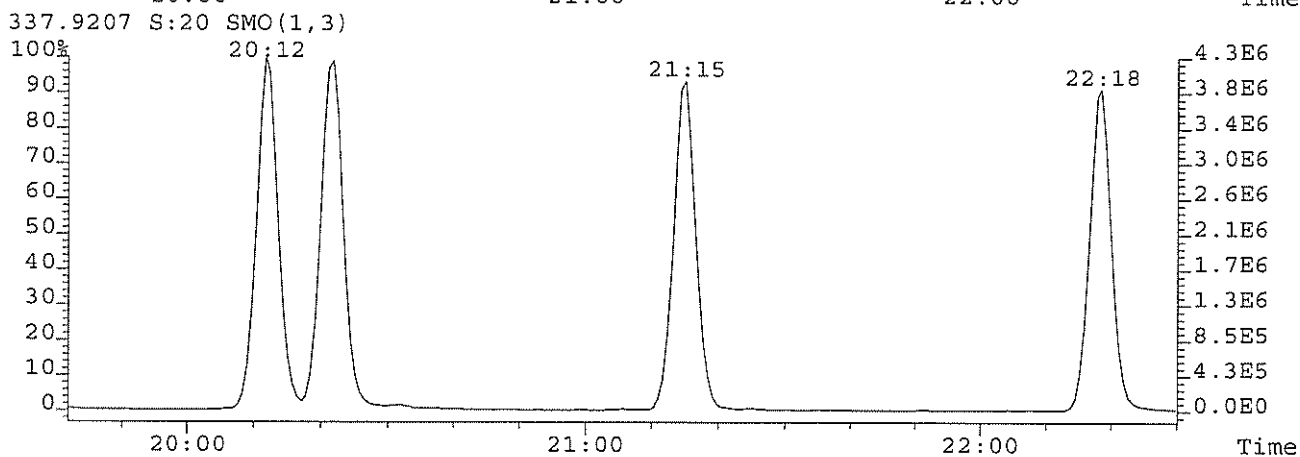
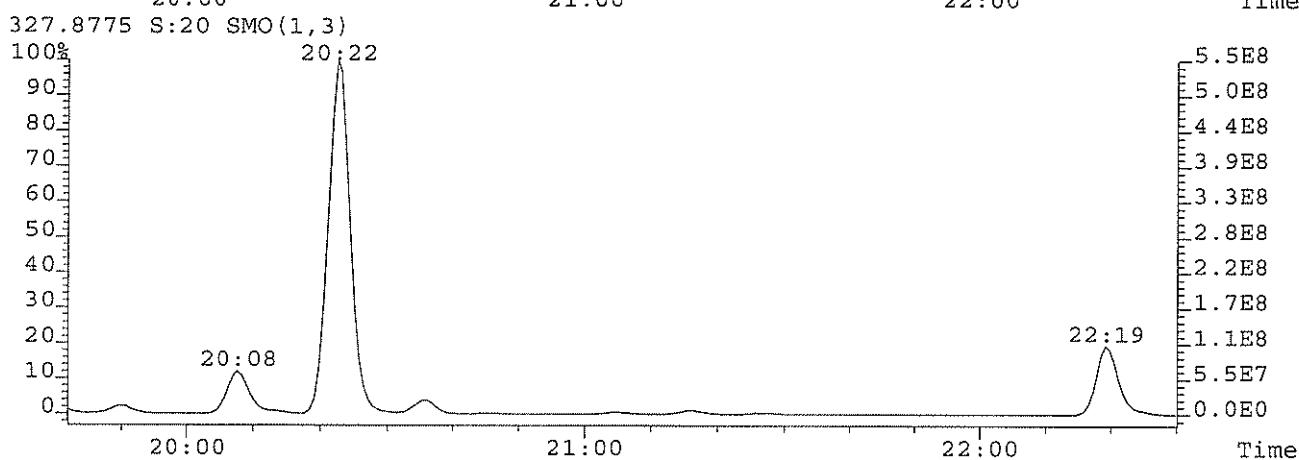
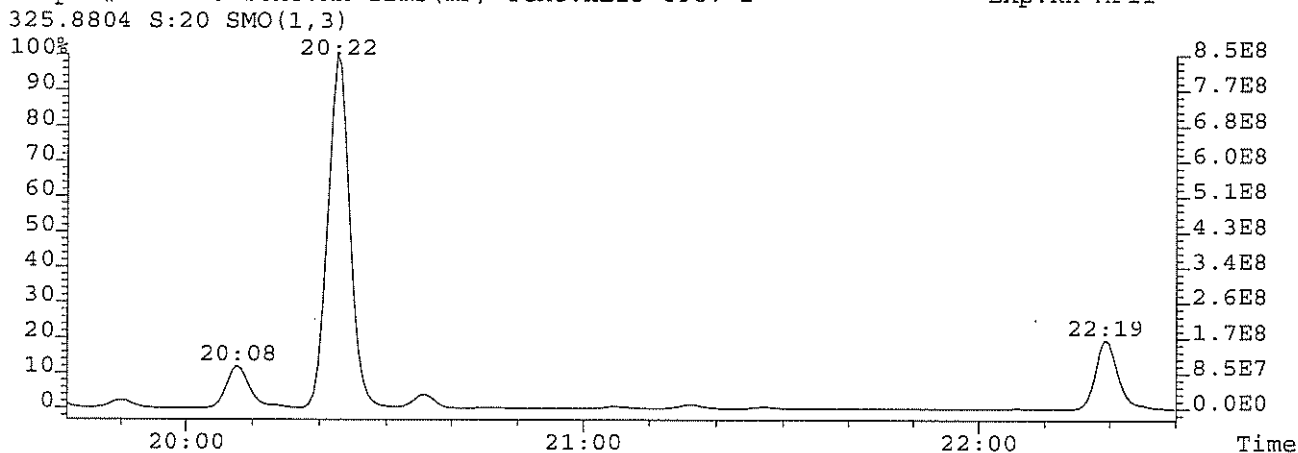
DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

File:130713 #1-1430 Acq:14-JUL-2013 04:44:29 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(5-8,nP) Text:XE13 0967 3 Exp:RH-PD22  
359.8415 S:21 SMO(1,3)



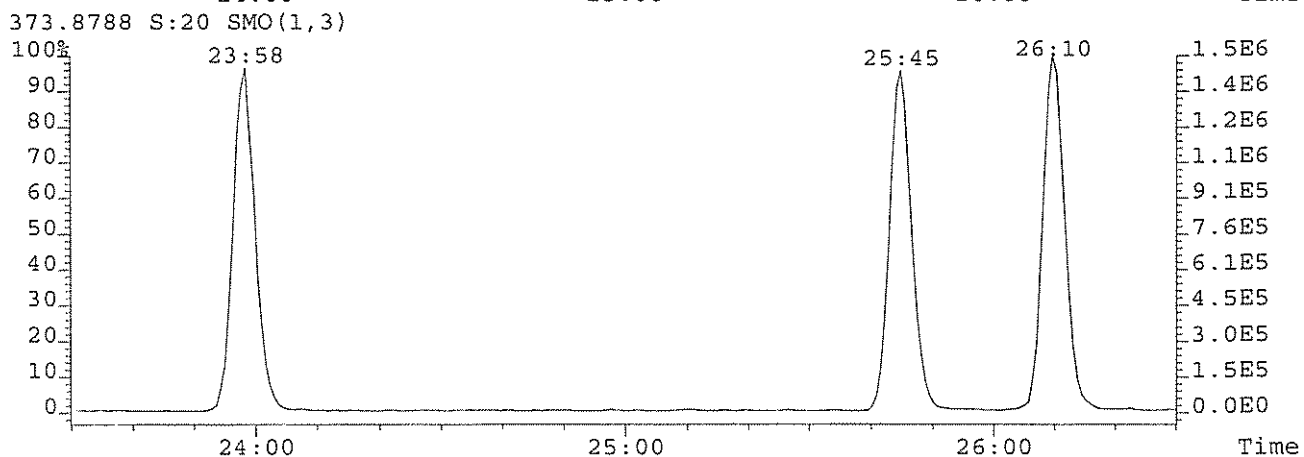
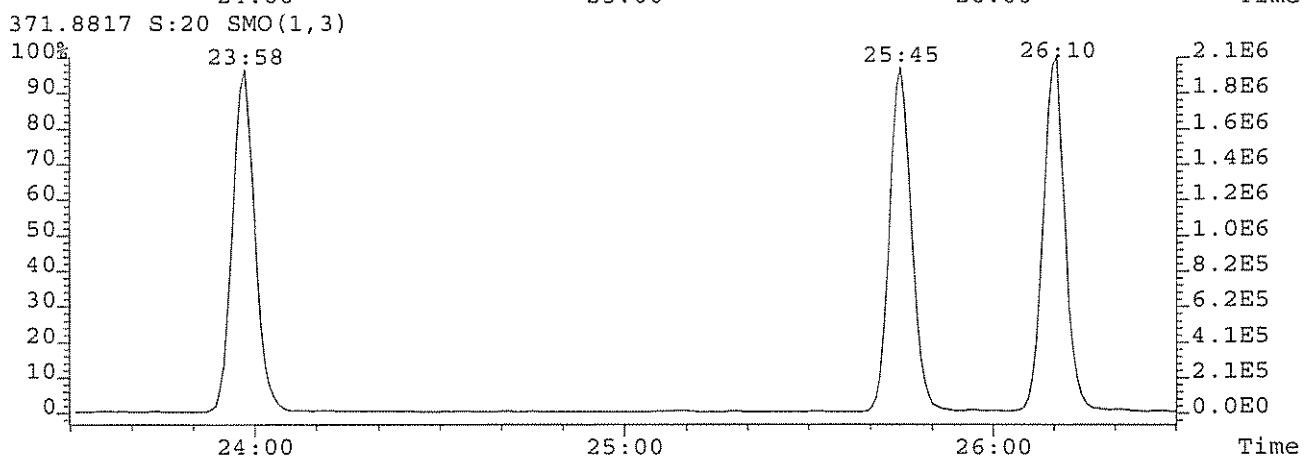
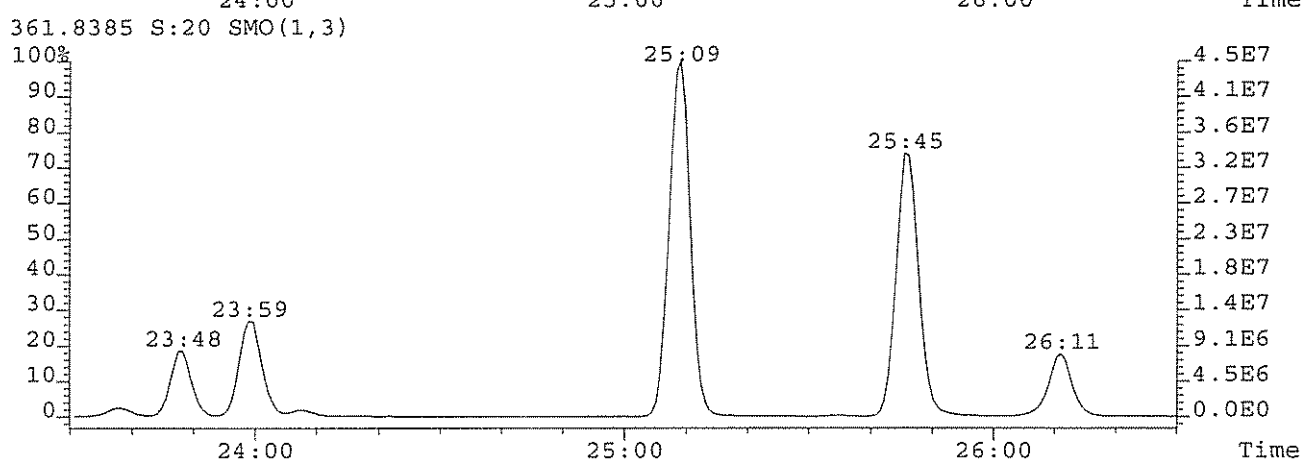
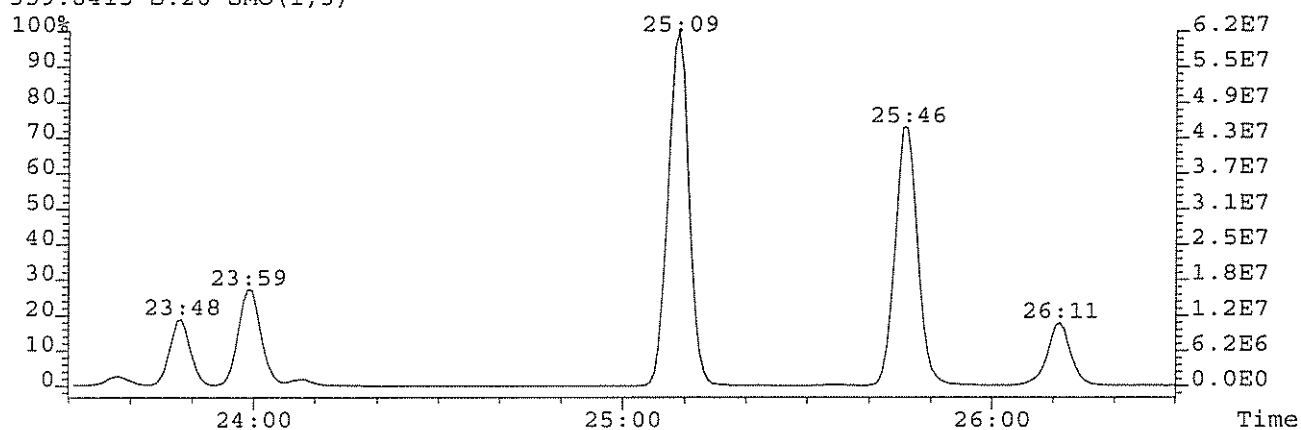
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130713 #1-2898 Acq:14-JUL-2013 01:18:54 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(mP) Text:XE13 0967 2 Exp:RH-MP11



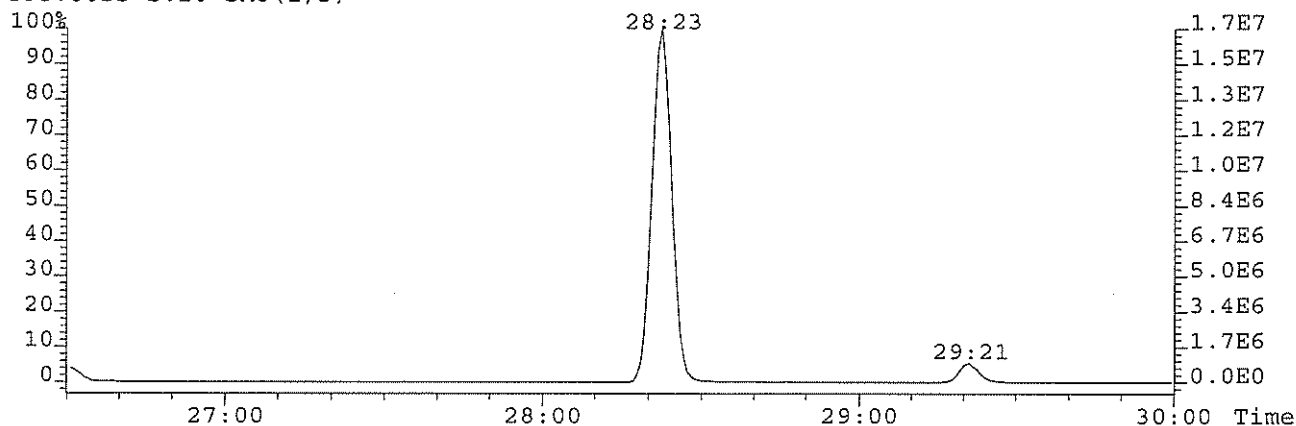
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130713 #1-2898 Acq:14-JUL-2013 01:18:54 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(mP) Text:XE13 0967 2 Exp:RH-MP11  
359.8415 S:20 SMO(1,3)

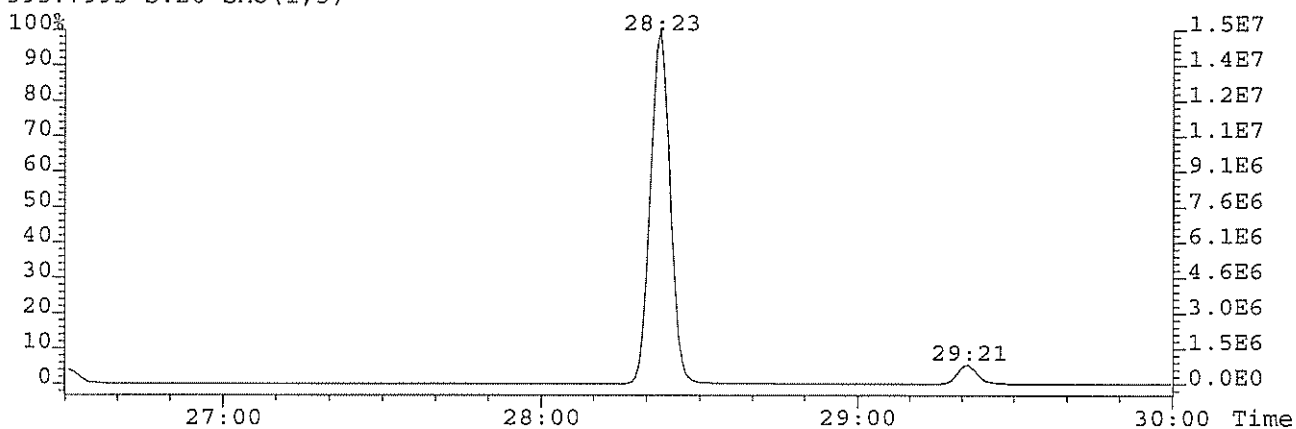


DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

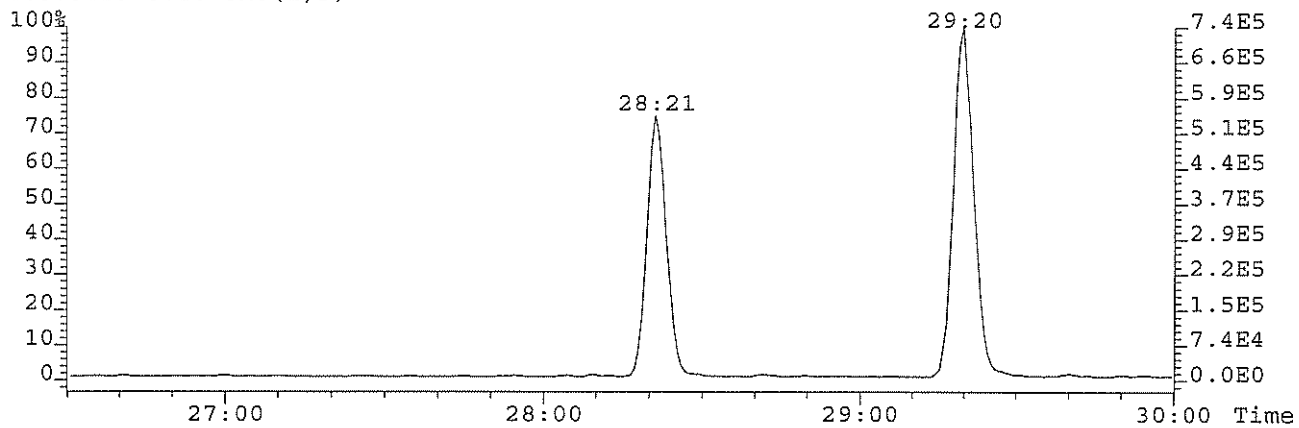
File:130713 #1-2898 Acq:14-JUL-2013 01:18:54 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#20 File Text:RH-12ms(mP) Text:XE13 0967 2 Exp:RH-MP11  
393.8025 S:20 SMO(1,3)



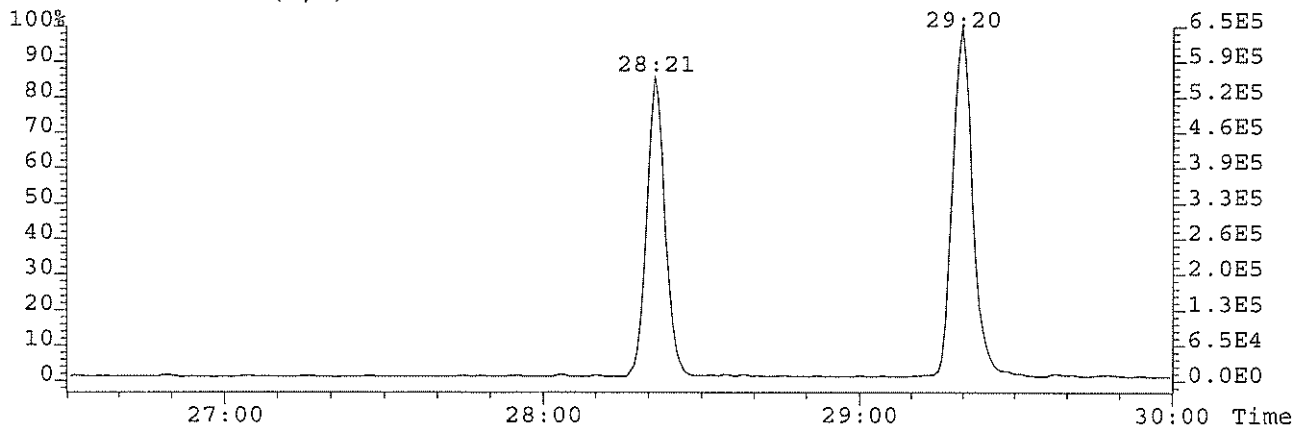
395.7995 S:20 SMO(1,3)



405.8428 S:20 SMO(1,3)



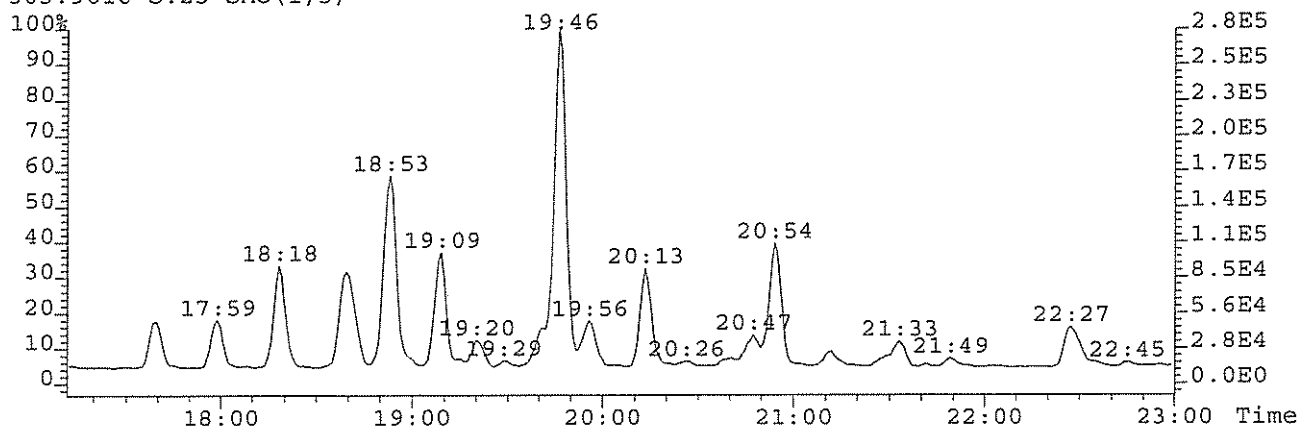
407.8398 S:20 SMO(1,3)



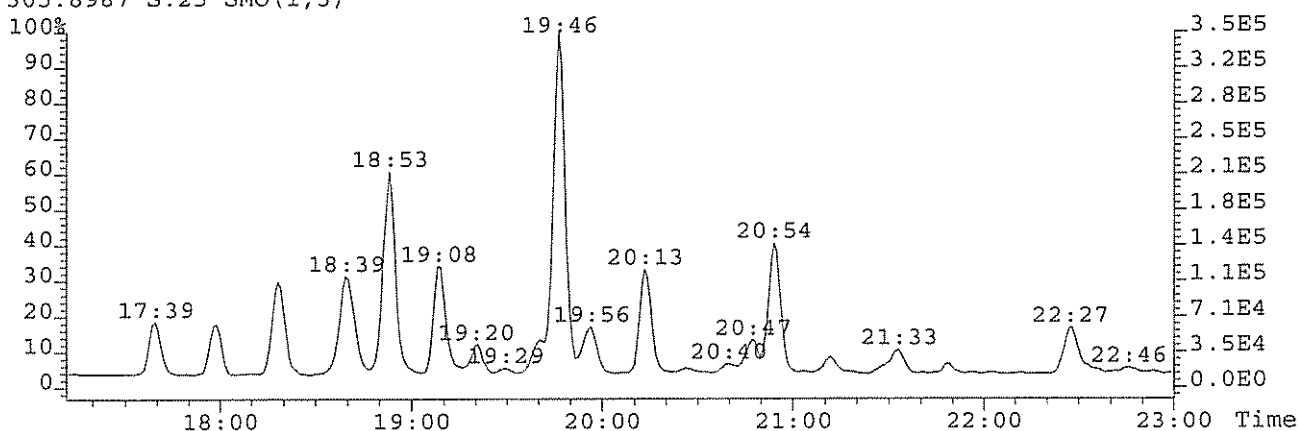
DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

試料管理番号	XE 130968
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物No.22

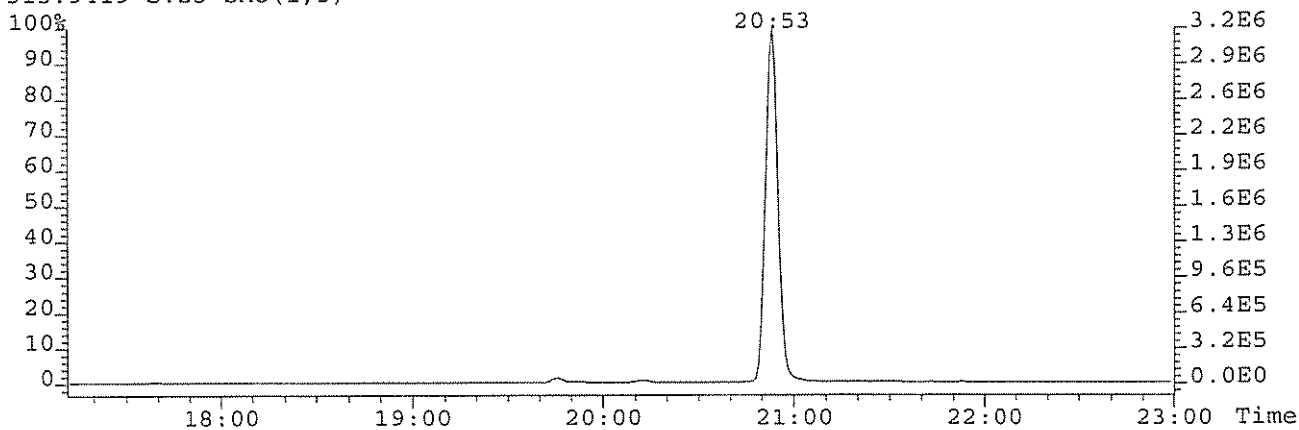
File:130712-2 #1-1578 Acq:13-JUL-2013 10:59:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#25 File Text:BPX-DXN(4-6DXN) Text:XE13 0968 Exp:BPX04  
303.9016 S:25 SMO(1,3)



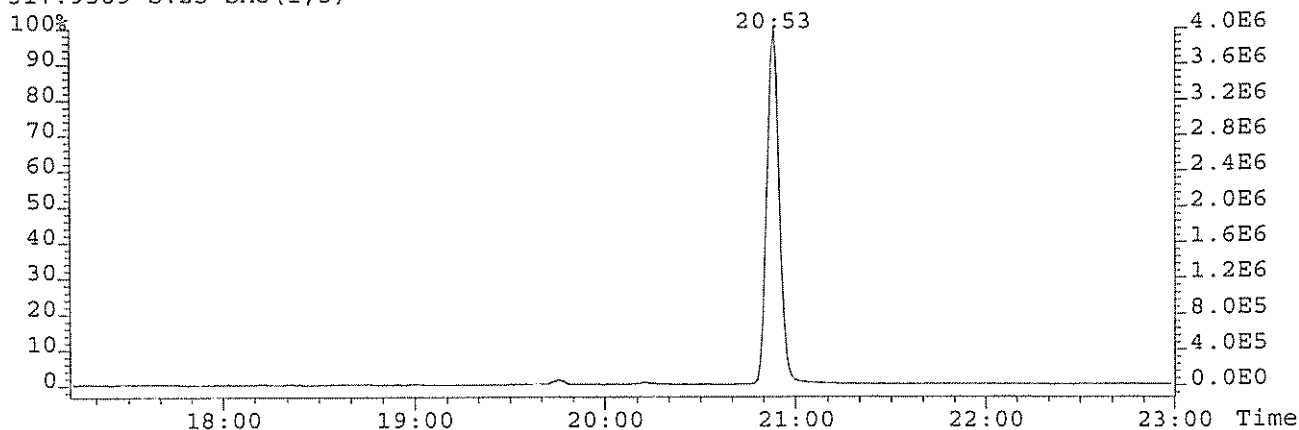
305.8987 S:25 SMO(1,3)



315.9419 S:25 SMO(1,3)

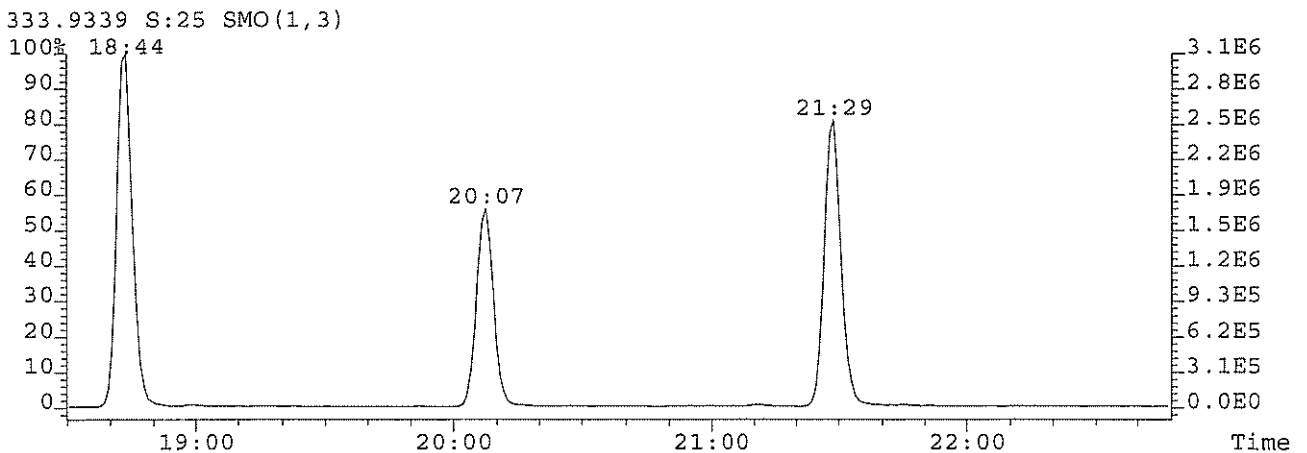
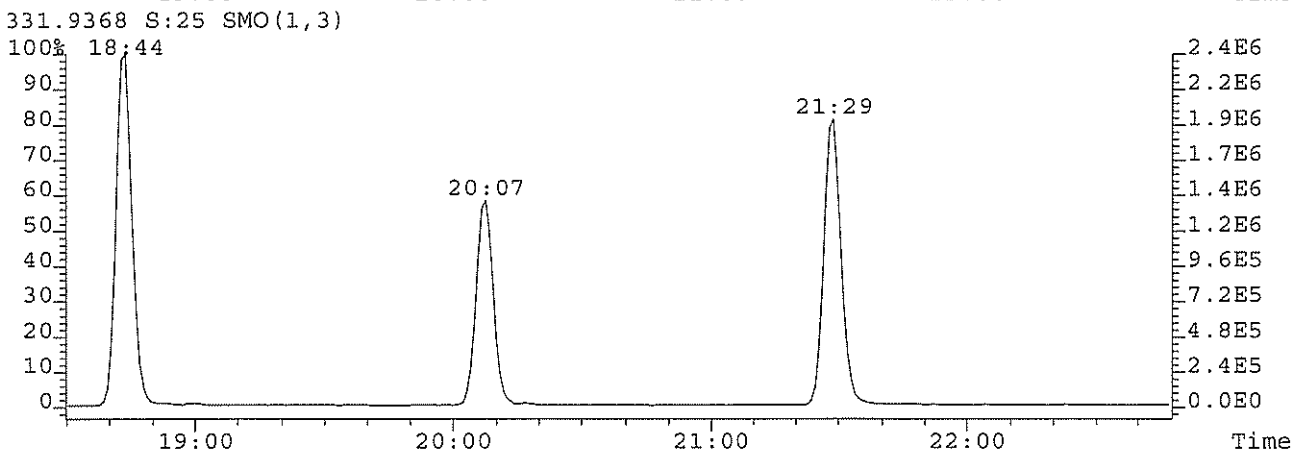
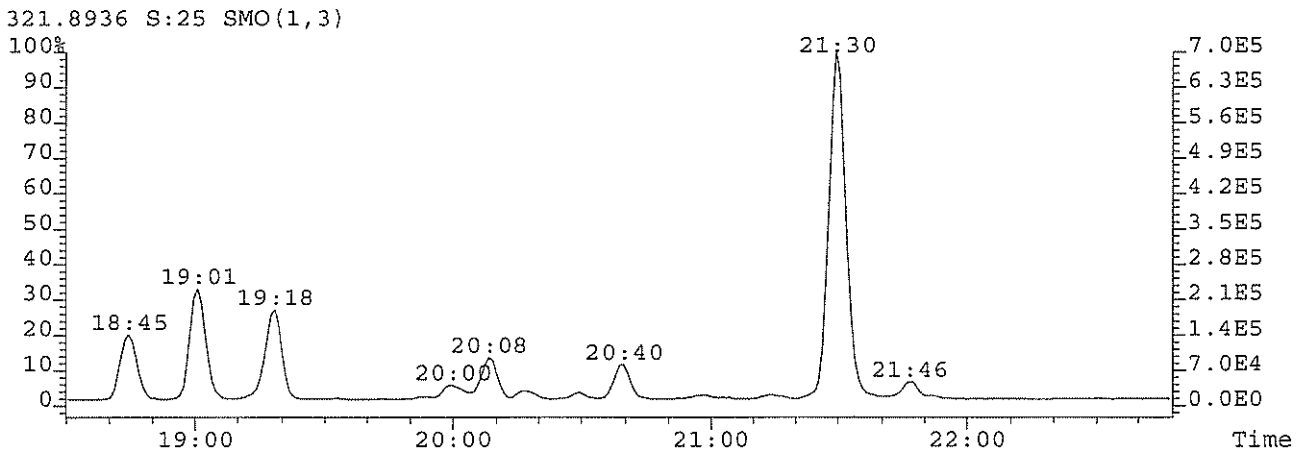
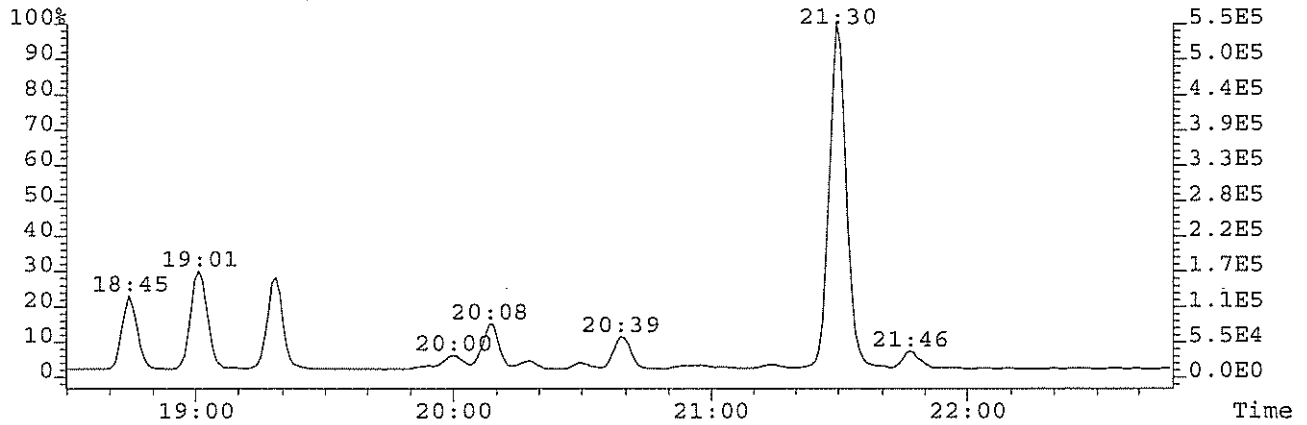


317.9389 S:25 SMO(1,3)



PCDFsクロマトグラム (1)  
(TeCDFs)

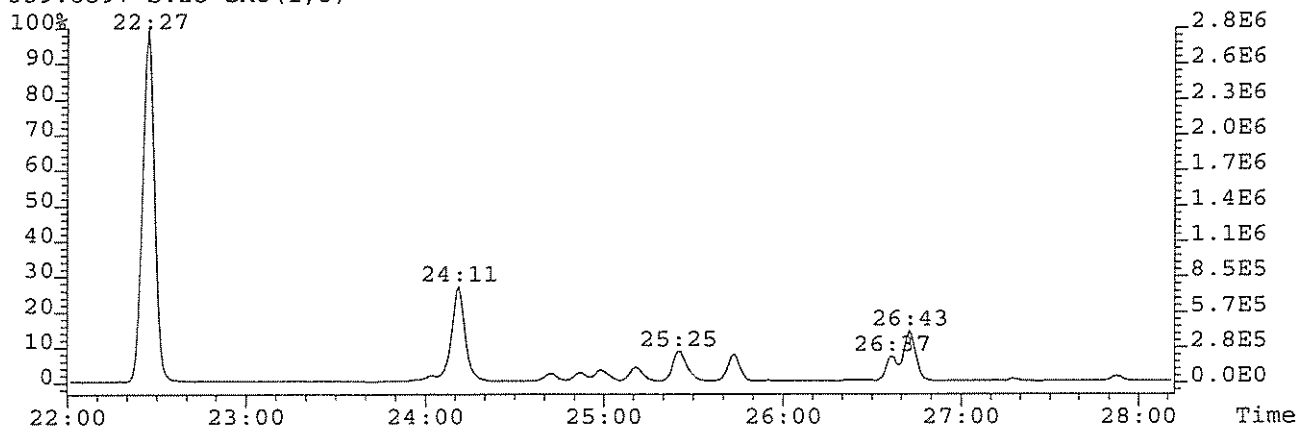
File:130712-2 #1-1578 Acq:13-JUL-2013 10:59:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#25 File Text:BPX-DXN(4-6DXN) Text:XE13 0968 Exp:BPX04  
319.8965 S:25 SMO(1,3)



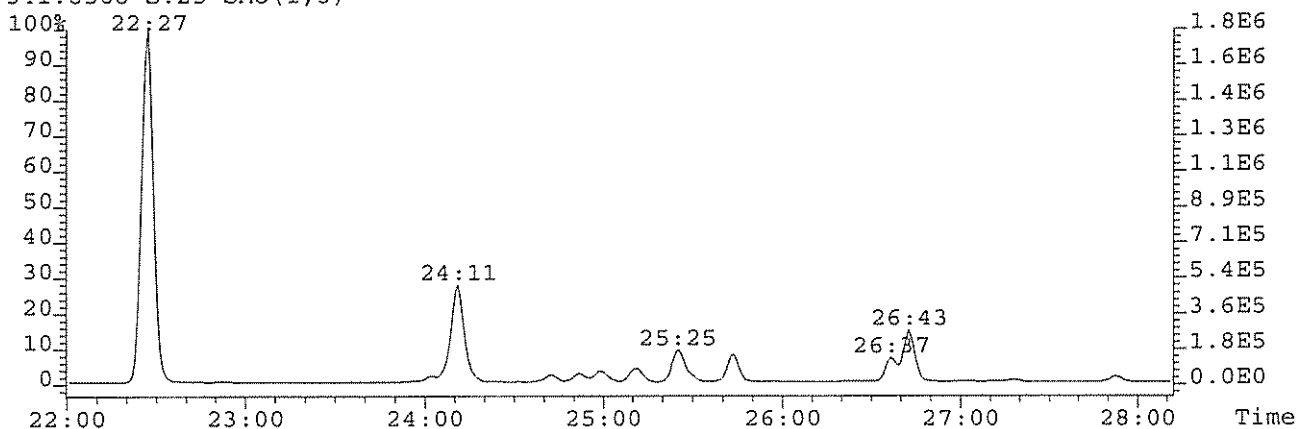
PCDDsクロマトグラム (2)  
(TeCDDs)



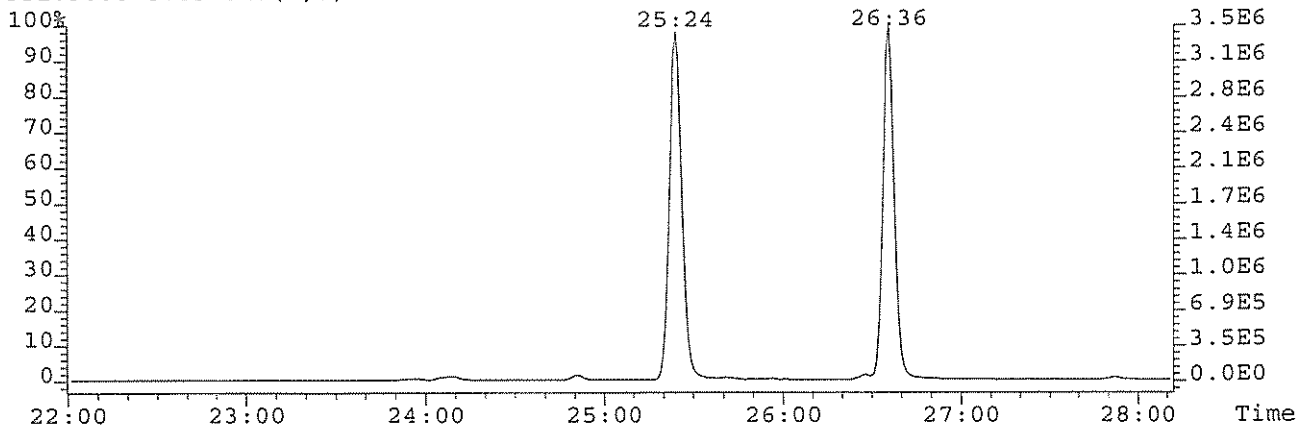
File:130712-2 #1-1578 Acq:13-JUL-2013 10:59:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#25 File Text:BPX-DXN(4-6DXN) Text:XE13 0968 Exp:BPX04  
339.8597 S:25 SMO(1,3)



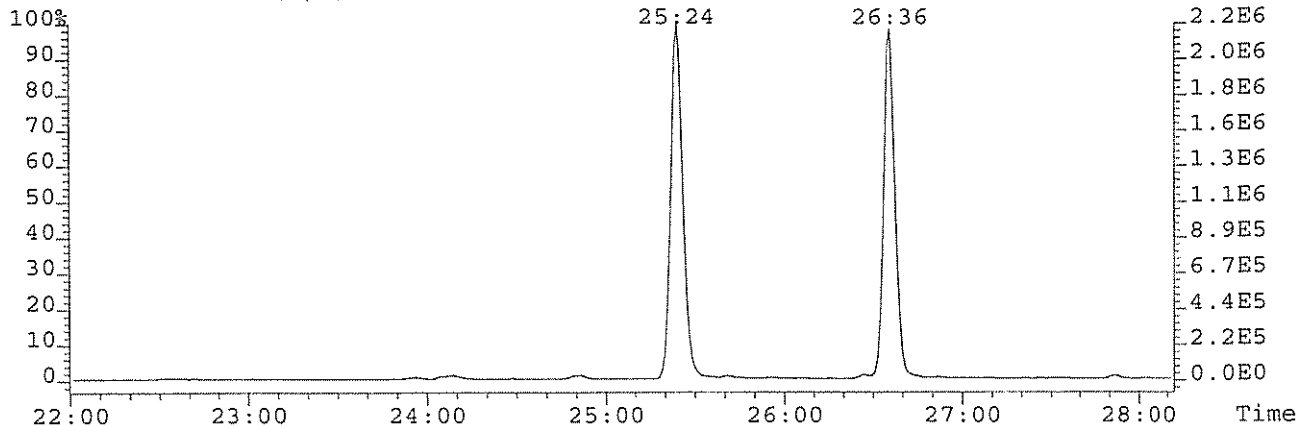
341.8568 S:25 SMO(1,3)



351.9000 S:25 SMO(1,3)



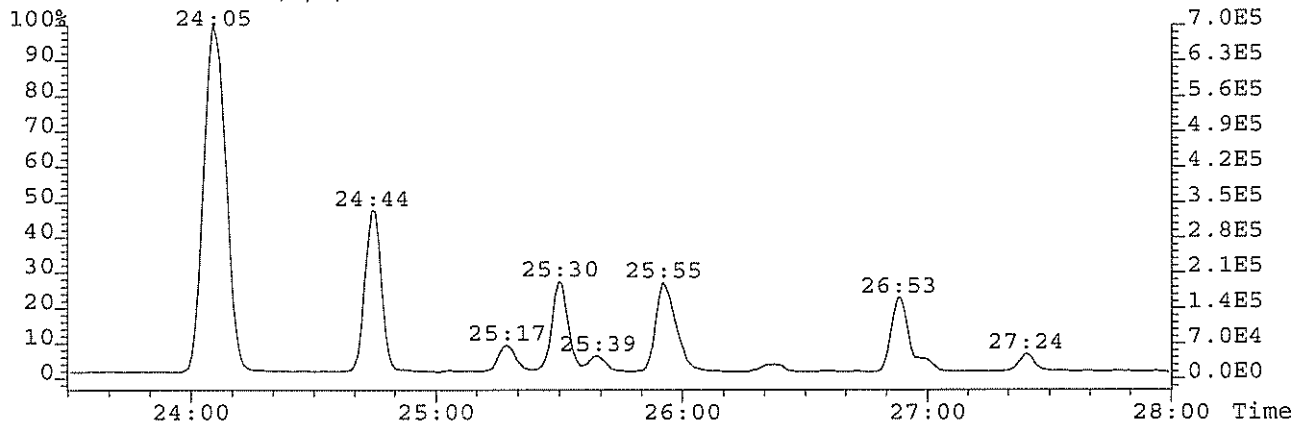
353.8970 S:25 SMO(1,3)



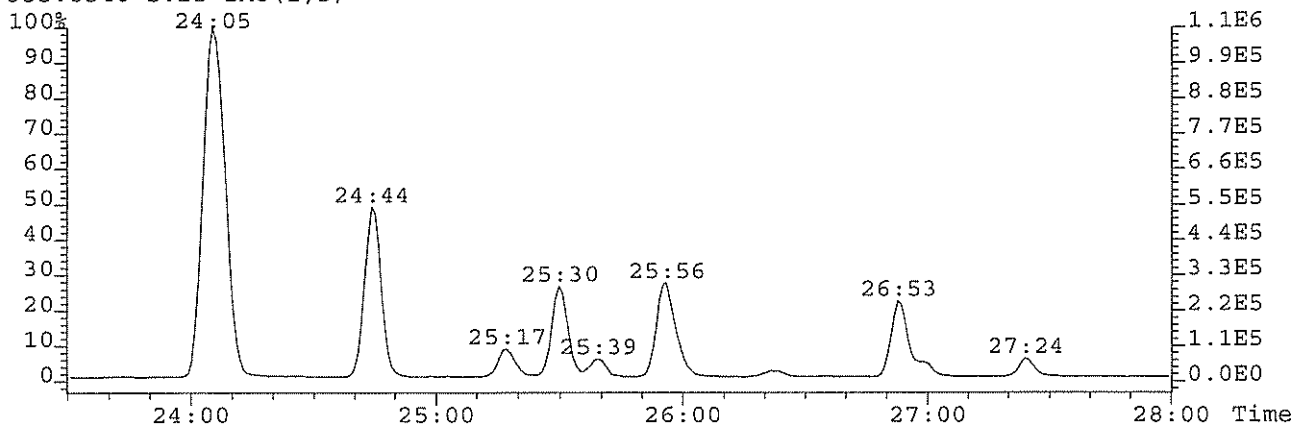
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712-2 #1-1578 Acq:13-JUL-2013 10:59:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#25 File Text:BPX-DXN(4-6DXN) Text:XE13 0968 Exp:BPX04

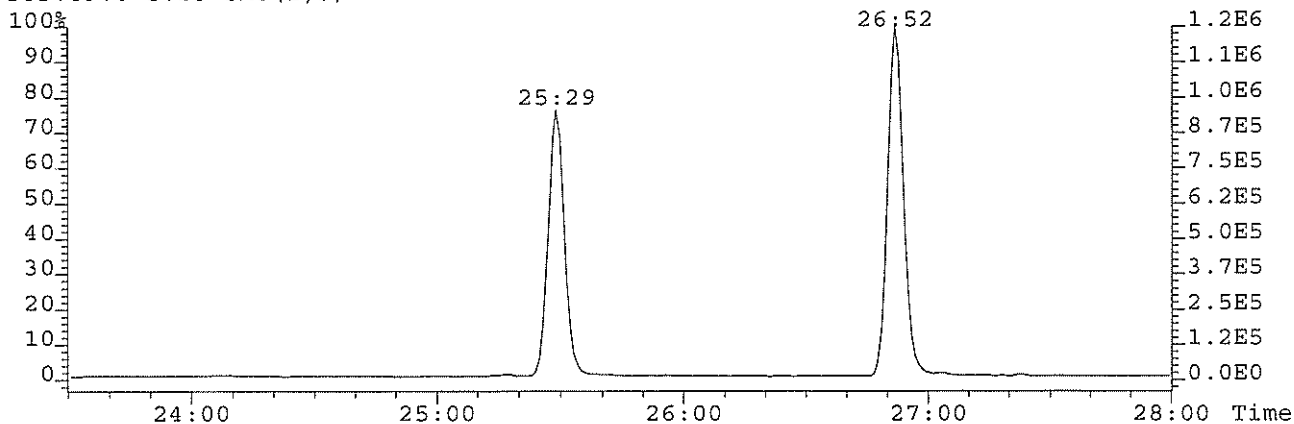
353.8576 S:25 SMO(1,3)



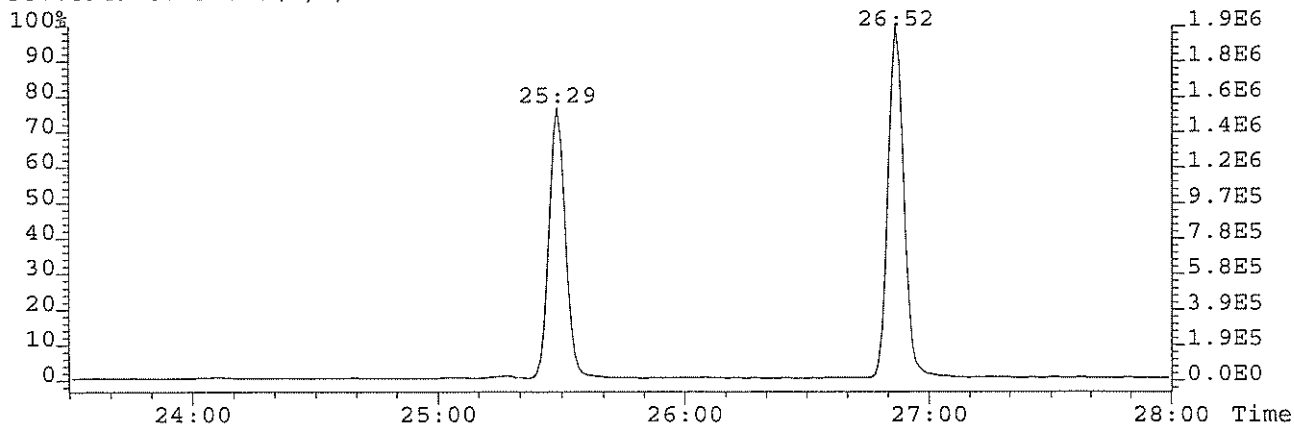
355.8546 S:25 SMO(1,3)



365.8978 S:25 SMO(1,3)

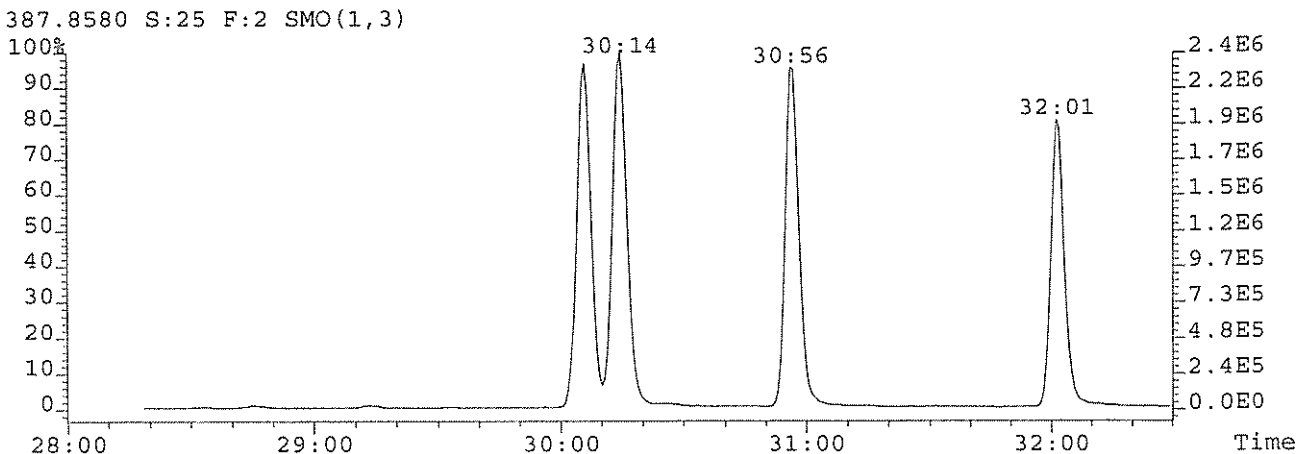
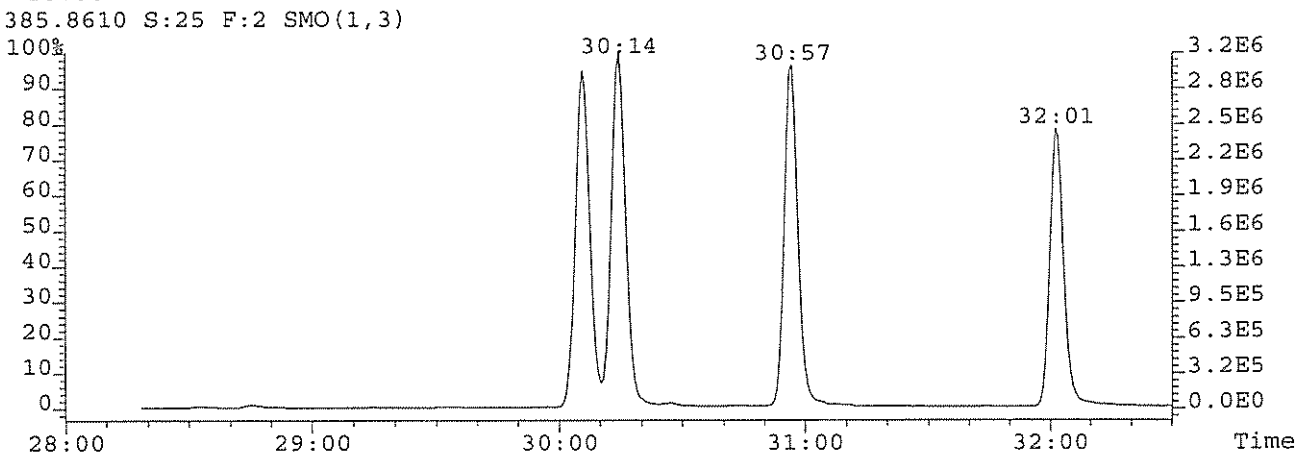
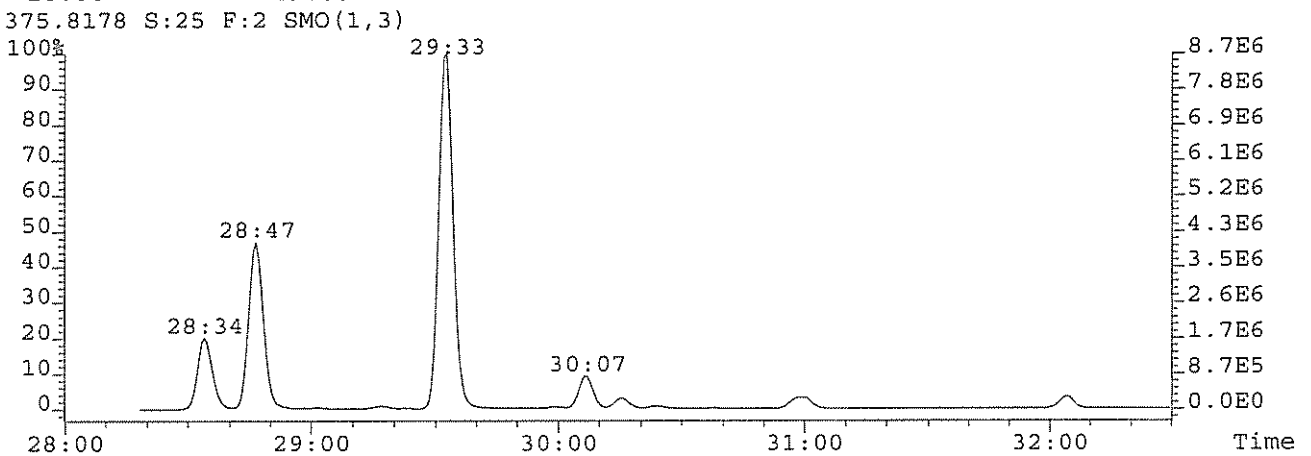
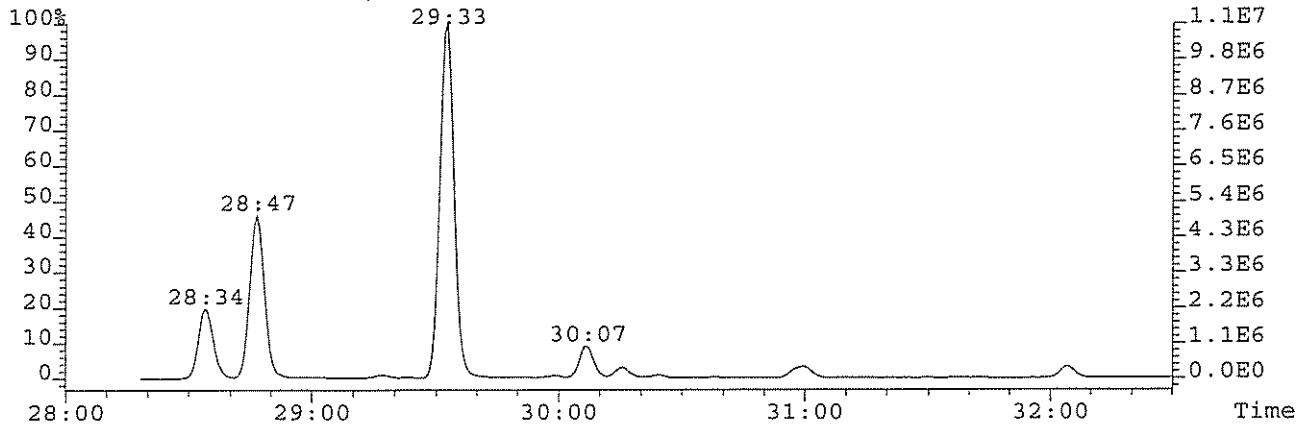


367.8949 S:25 SMO(1,3)



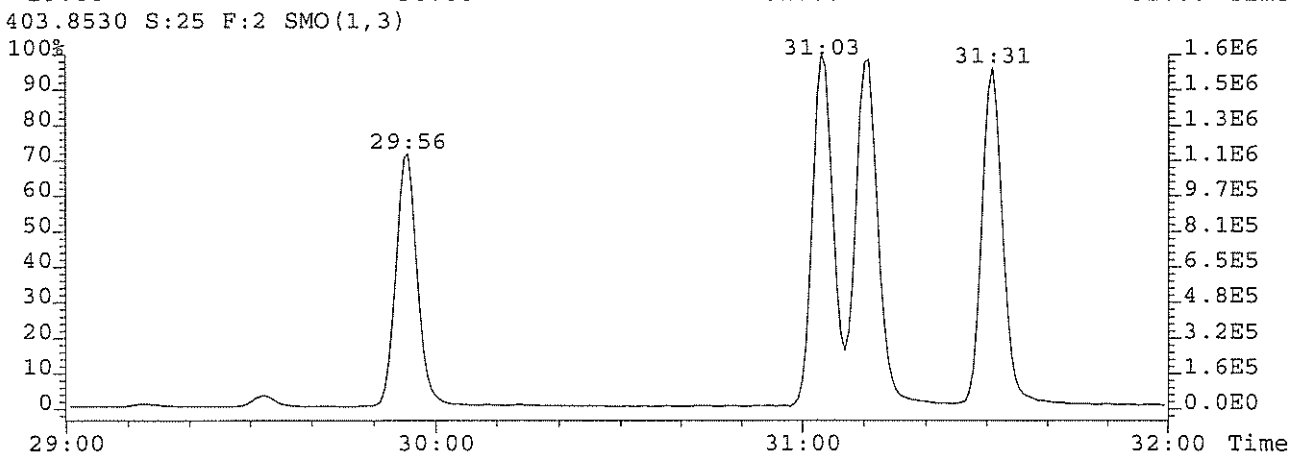
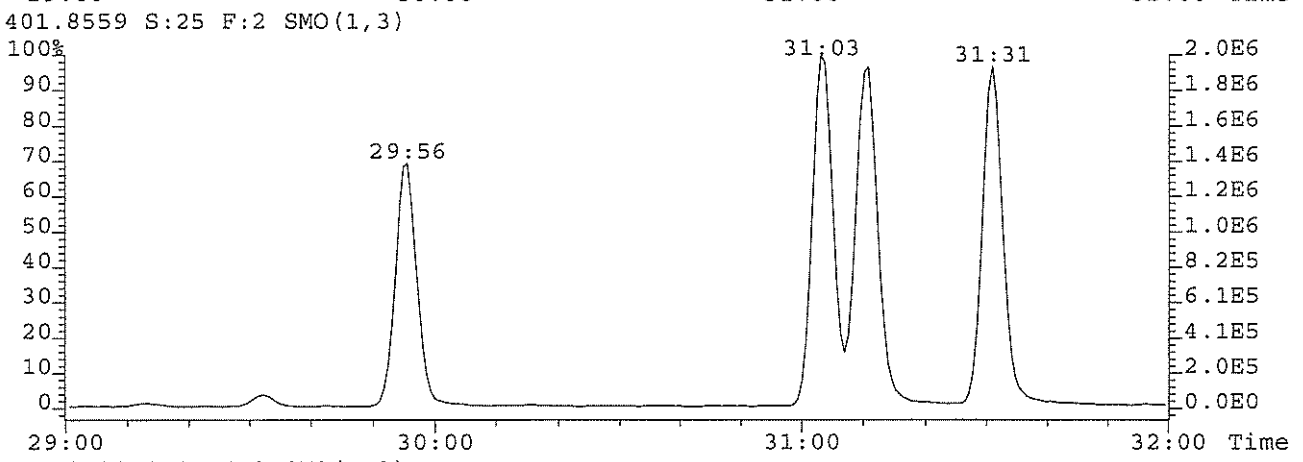
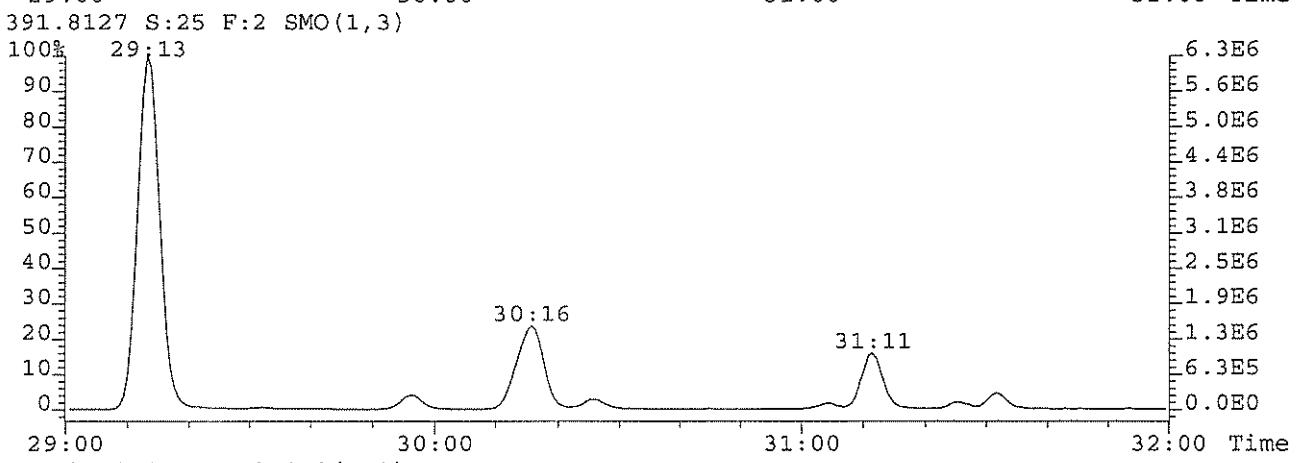
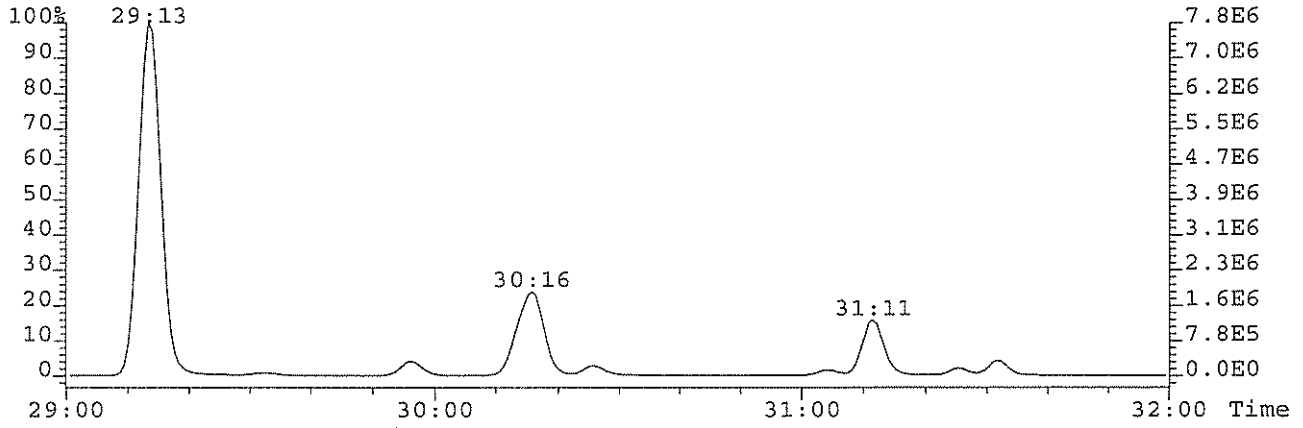
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130712-2 #1-1117 Acq:13-JUL-2013 10:59:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#25 File Text:BPX-DXN(4-6DXN) Text:XE13 0968 Exp:BPX04  
373.8207 S:25 F:2 SMO(1,3)



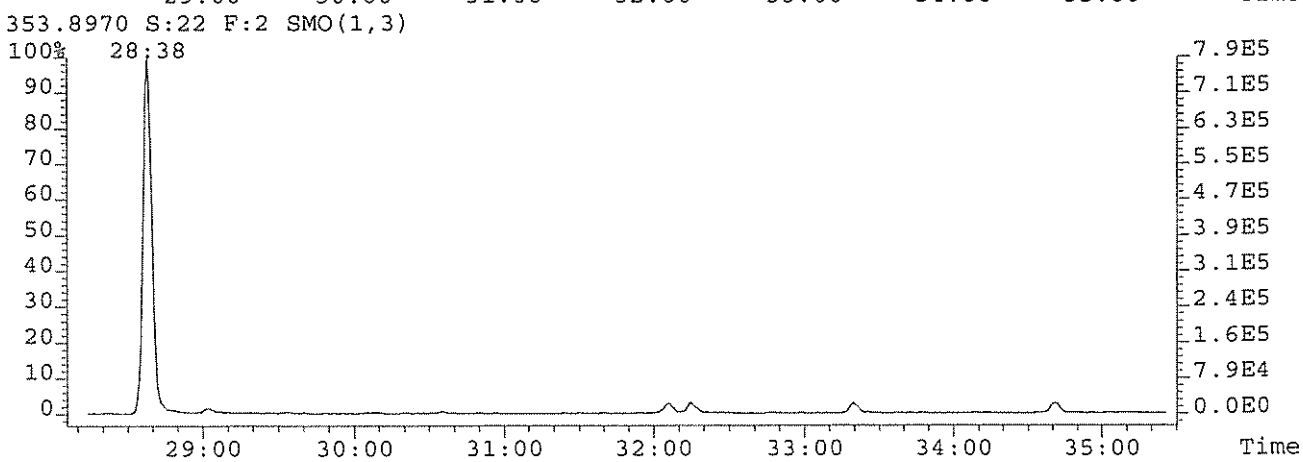
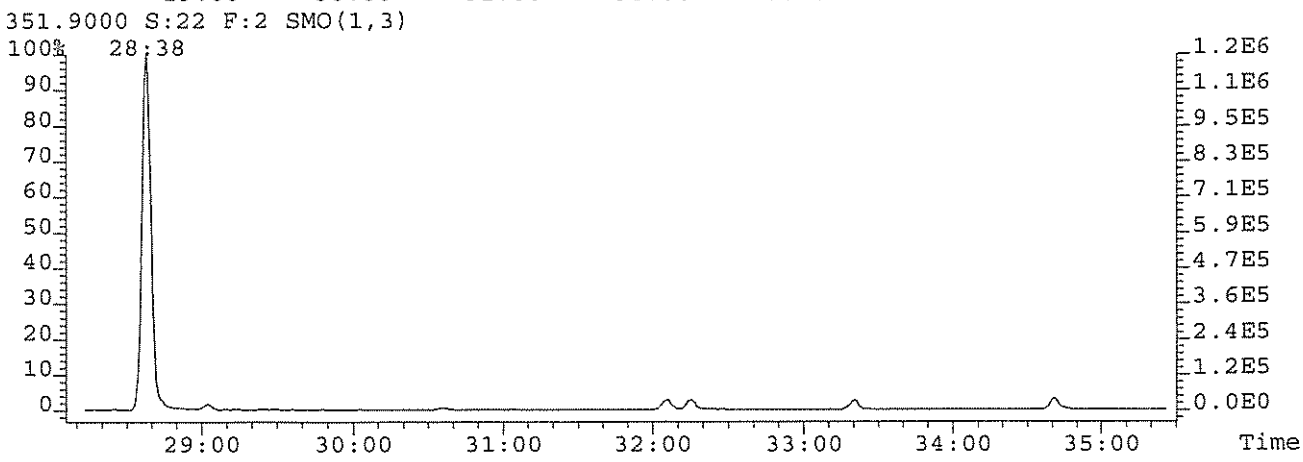
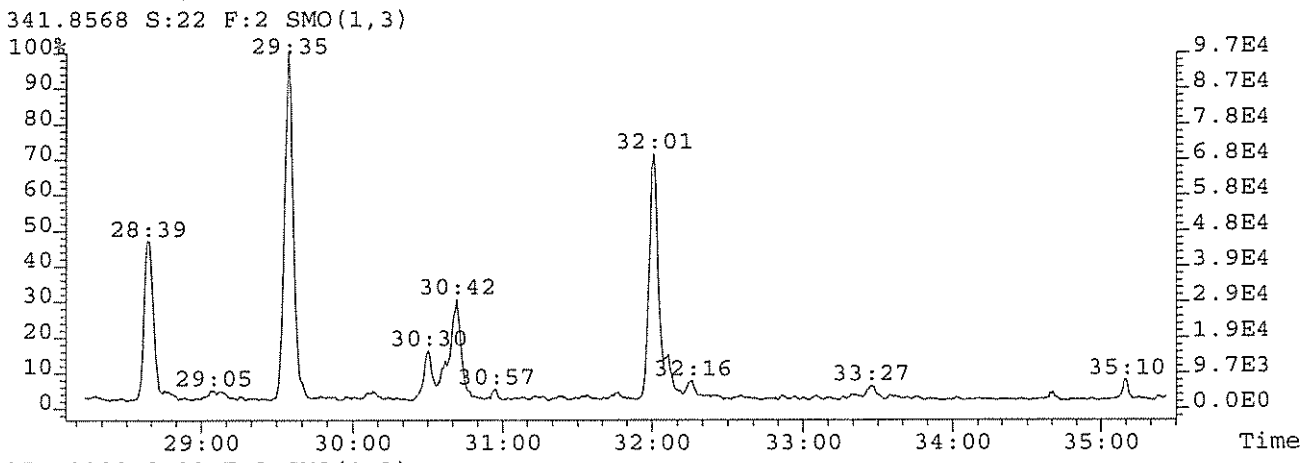
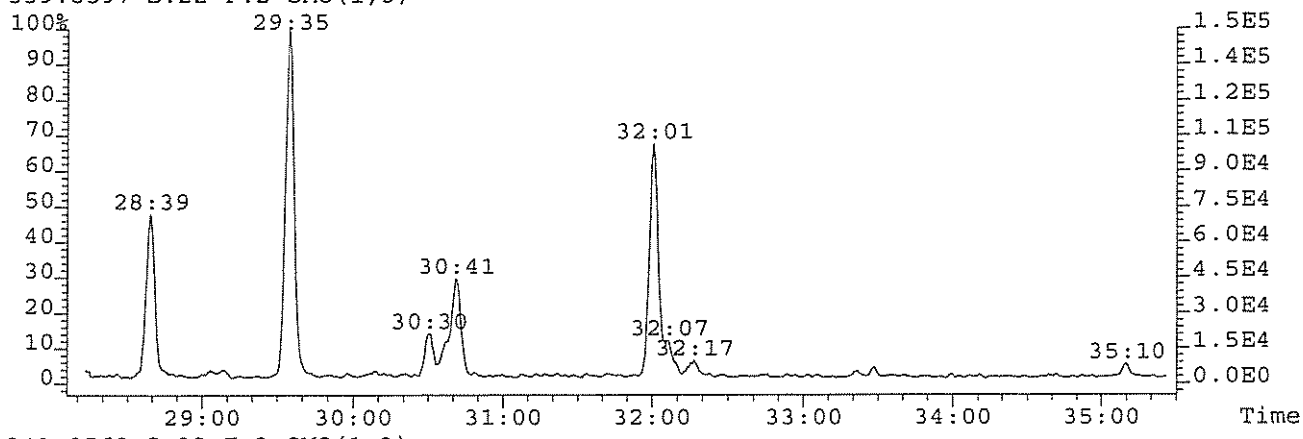
PCDFsクロマトグラム (5)  
(HxCDFs)

File:130712-2 #1-1117 Acq:13-JUL-2013 10:59:01 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#25 File Text:BPX-DXN(4-6DXN) Text:XE13 0968 Exp:BPX04  
389.8156 S:25 F:2 SMO(1,3)



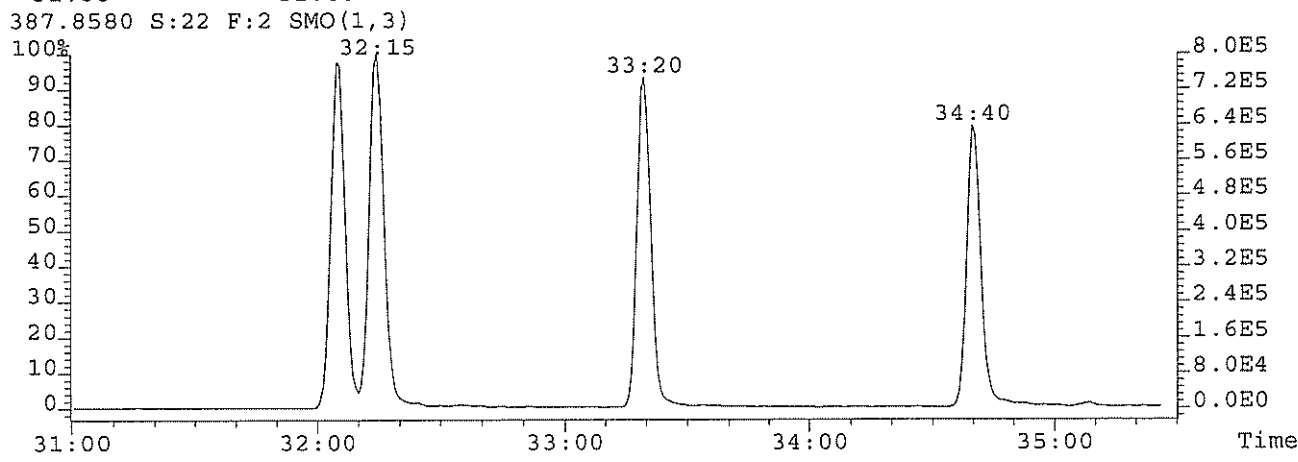
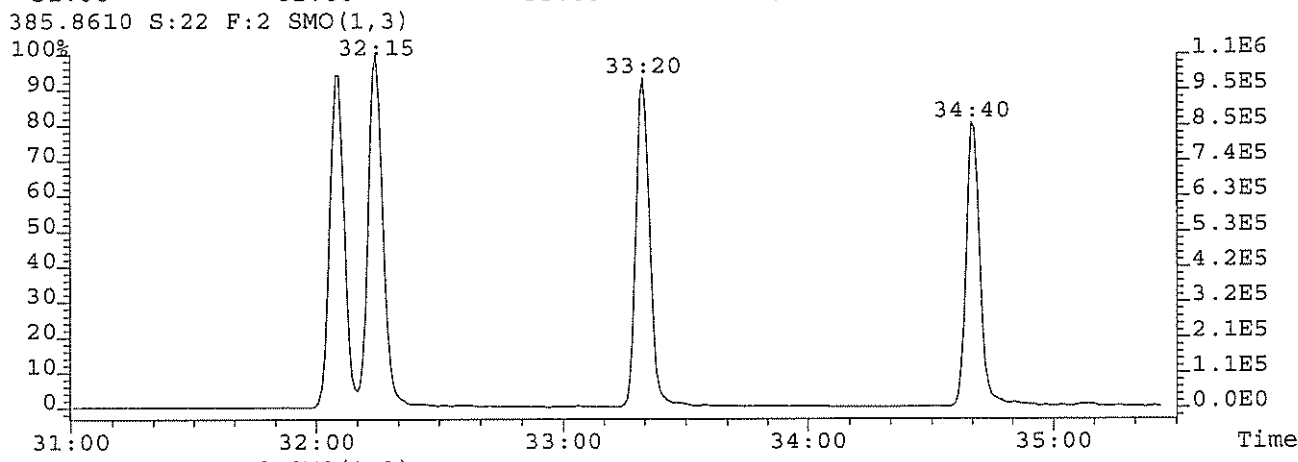
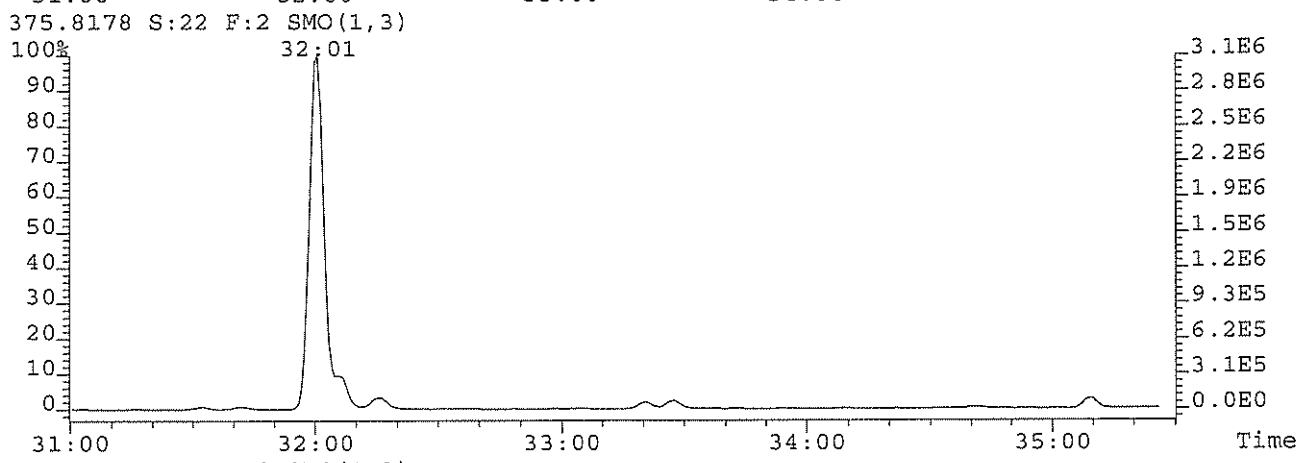
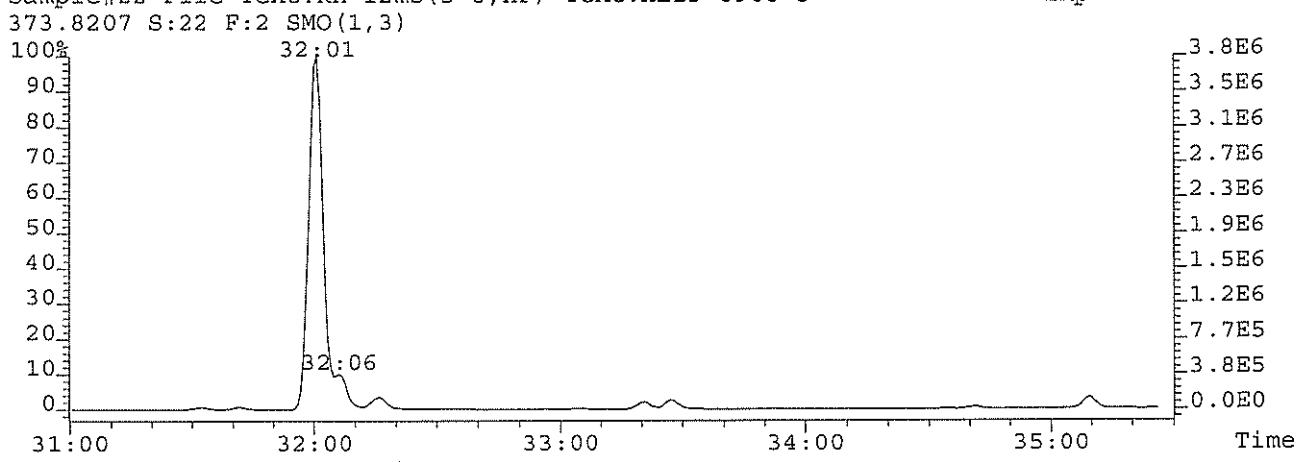
PCDDsクロマトグラム (6)  
(HxCDDs)

File:130713 #1-648 Acq:14-JUL-2013 05:33:45 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0968 3 Exp:RH-PD22  
339.8597 S:22 F:2 SMO(1,3)



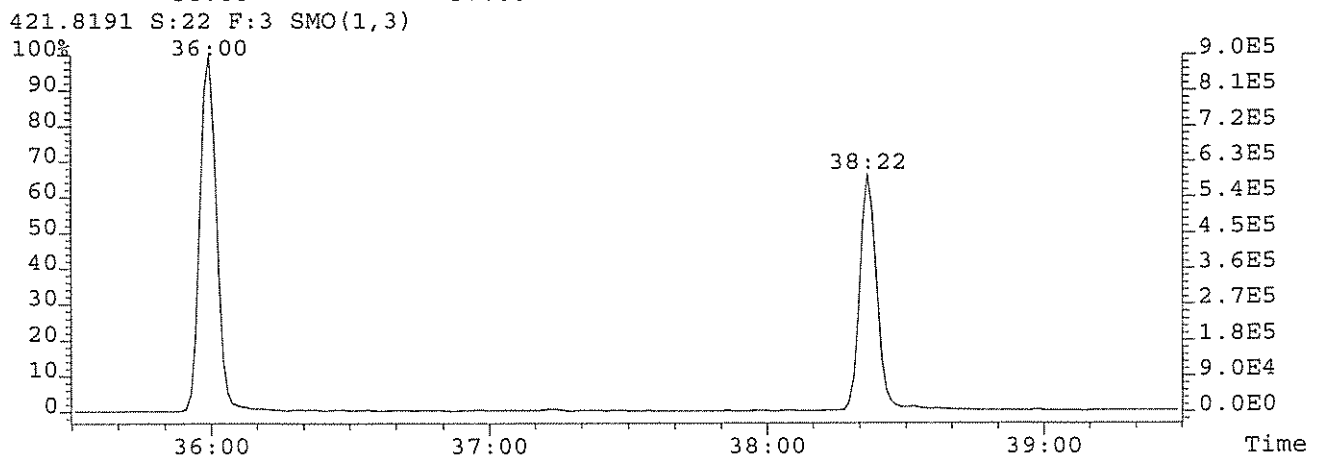
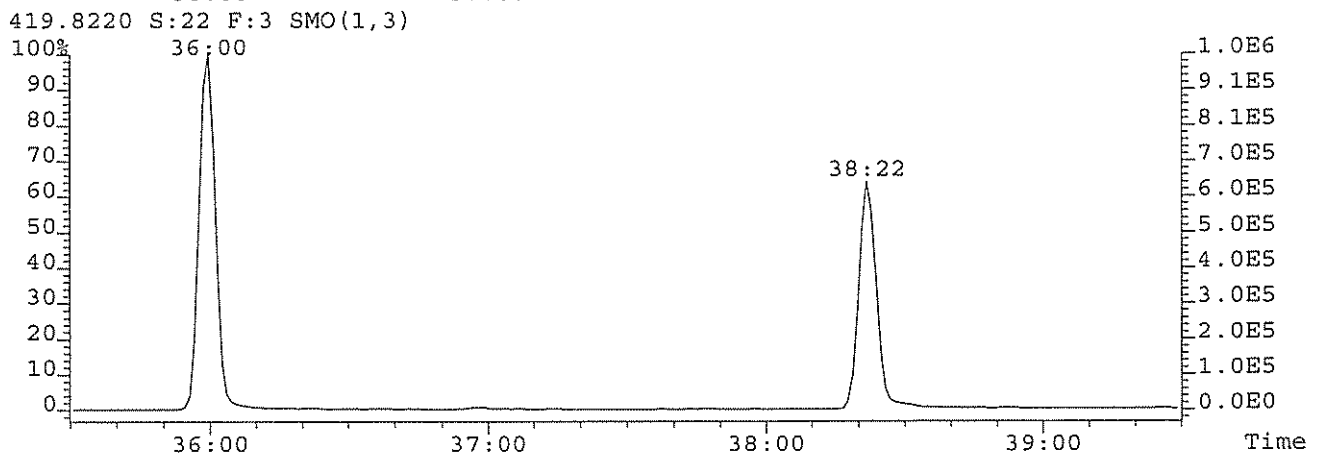
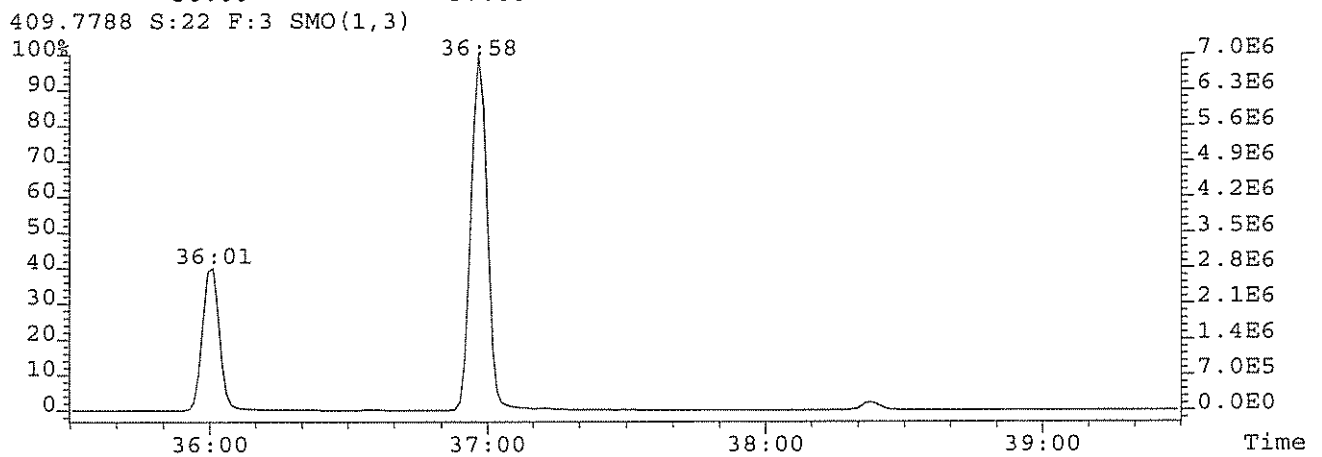
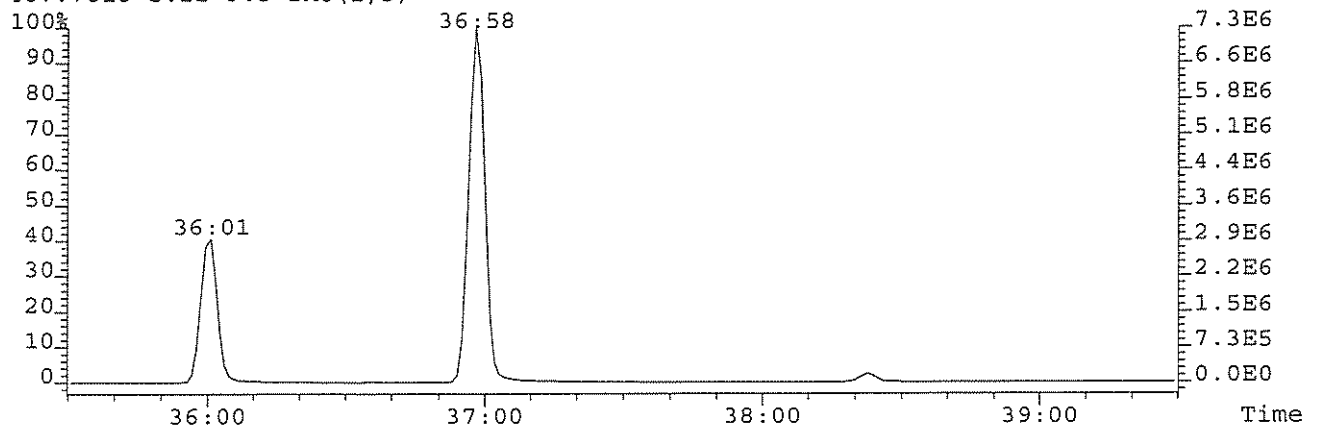
PeCDFsクロマトグラム (7)  
(23478-PeCDF)

File:130713 #1-648 Acq:14-JUL-2013 05:33:45 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0968 3 Exp:RH-PD22



HxCDFsクロマトグラム (8)  
(123789-HxCDF)

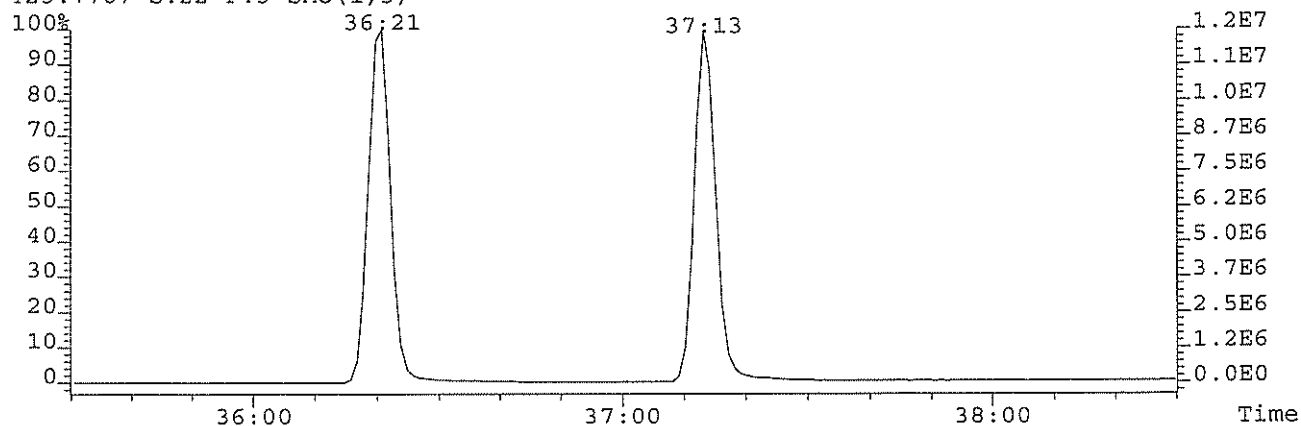
File:130713 #1-561 Acq:14-JUL-2013 05:33:45 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0968 3 Exp:RH-PD22  
407.7818 S:22 F:3 SMO(1,3)



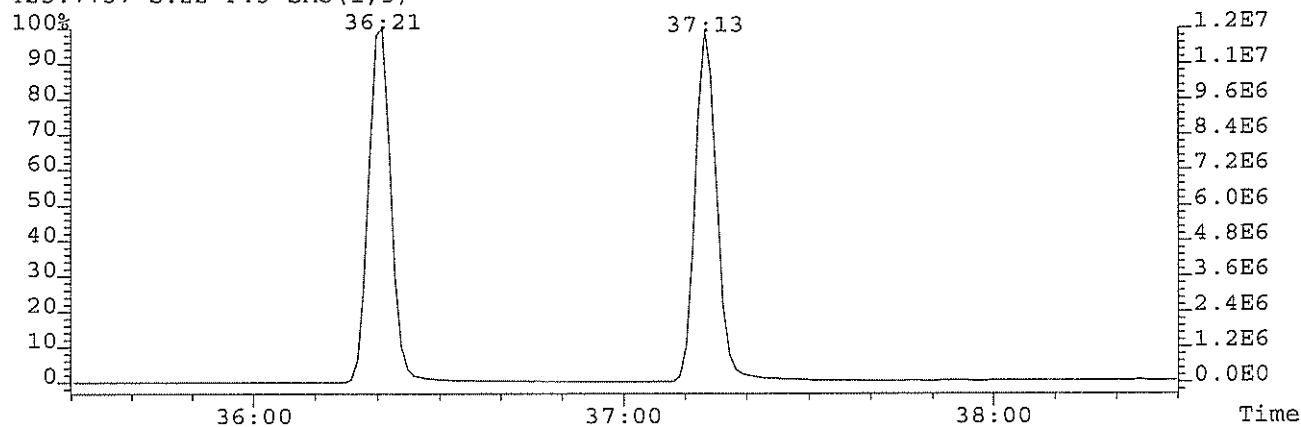
PCDFsクロマトグラム (9)  
(HpCDFs)

File:130713 #1-561 Acq:14-JUL-2013 05:33:45 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0968 3 Exp:RH-PD22

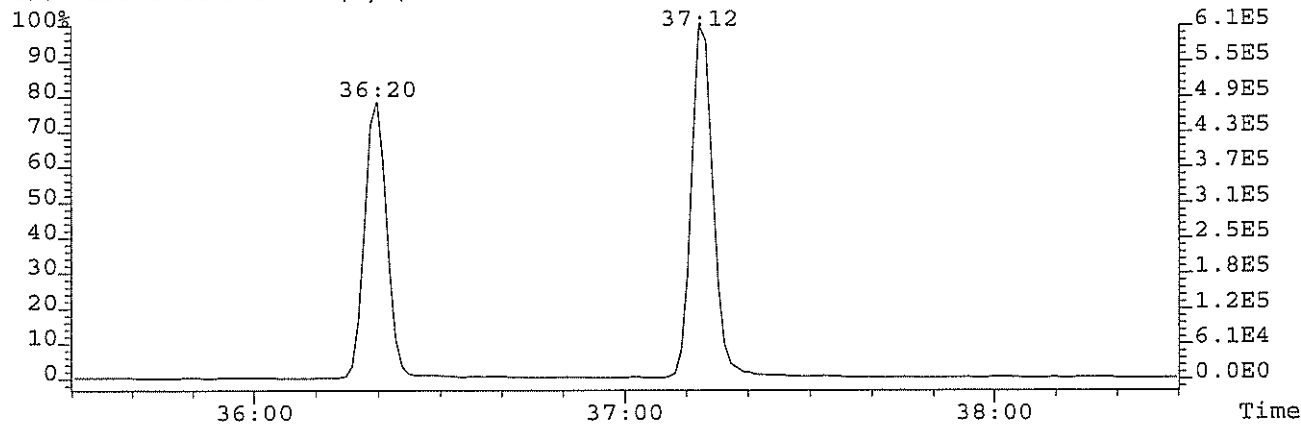
423.7767 S:22 F:3 SMO(1,3)



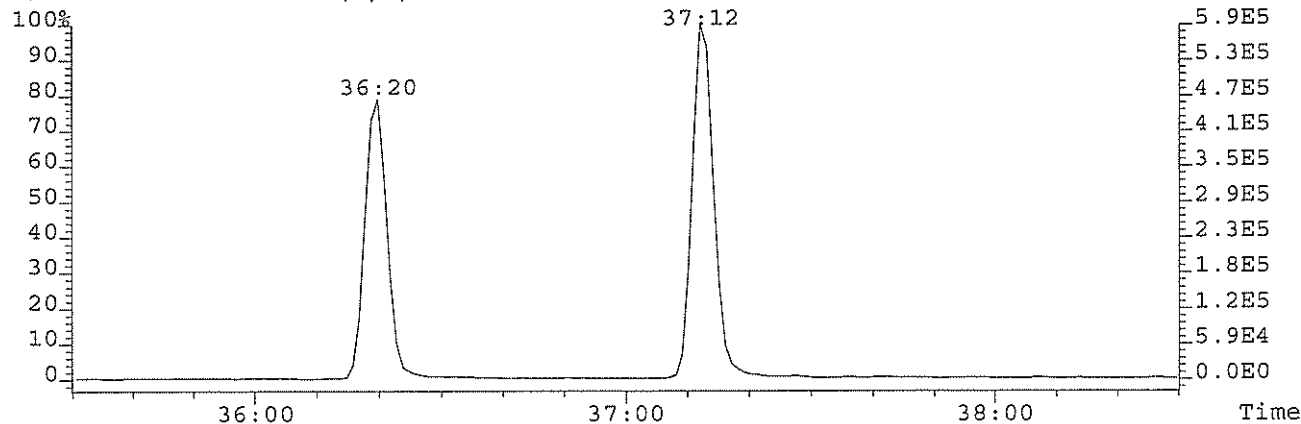
425.7737 S:22 F:3 SMO(1,3)



435.8169 S:22 F:3 SMO(1,3)



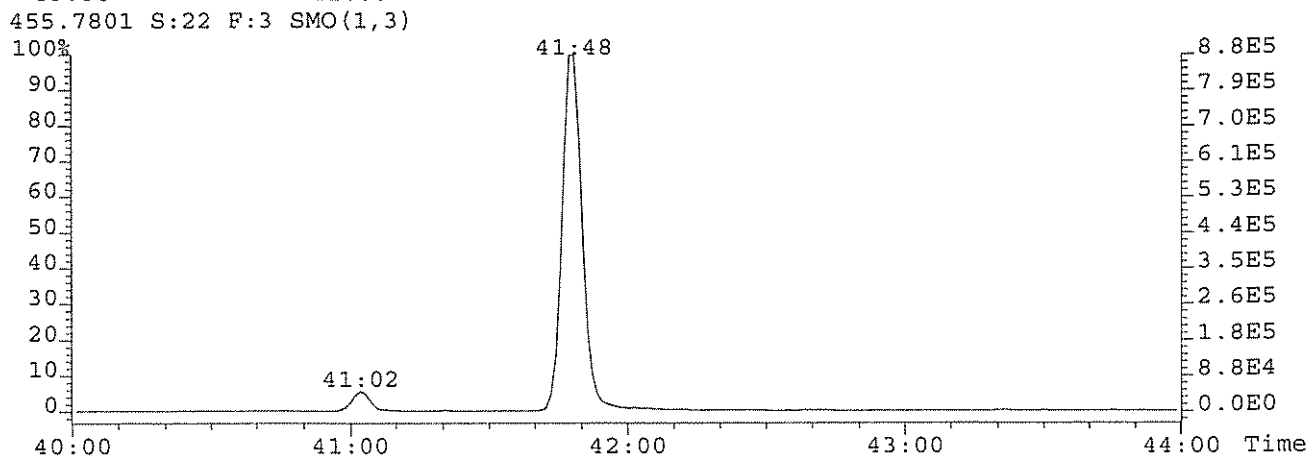
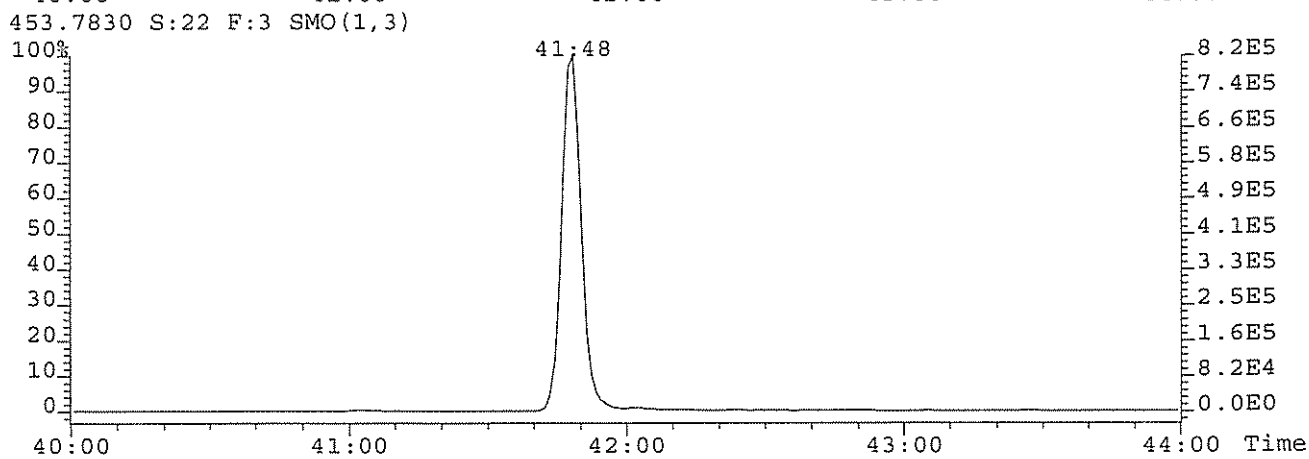
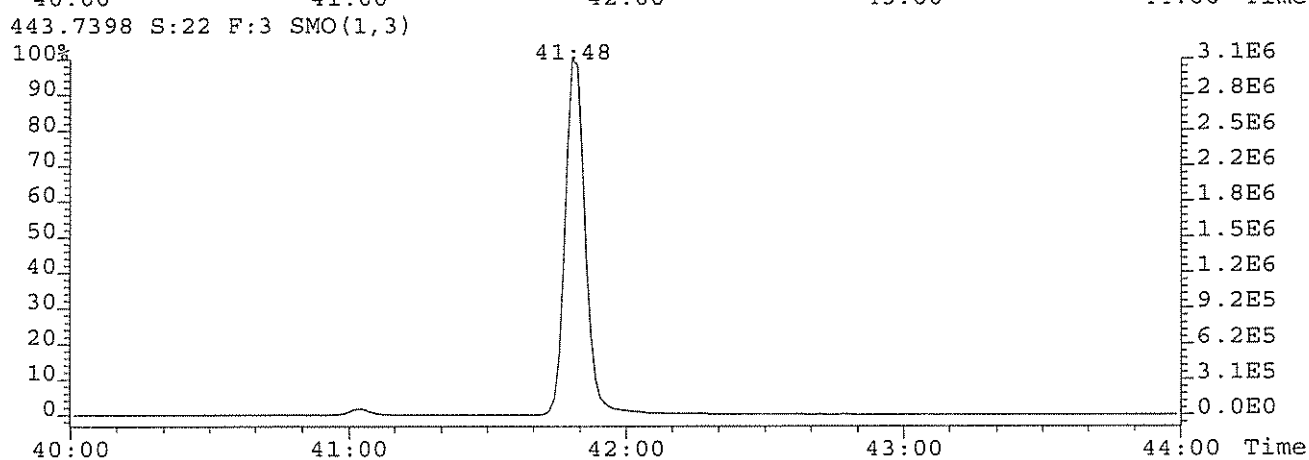
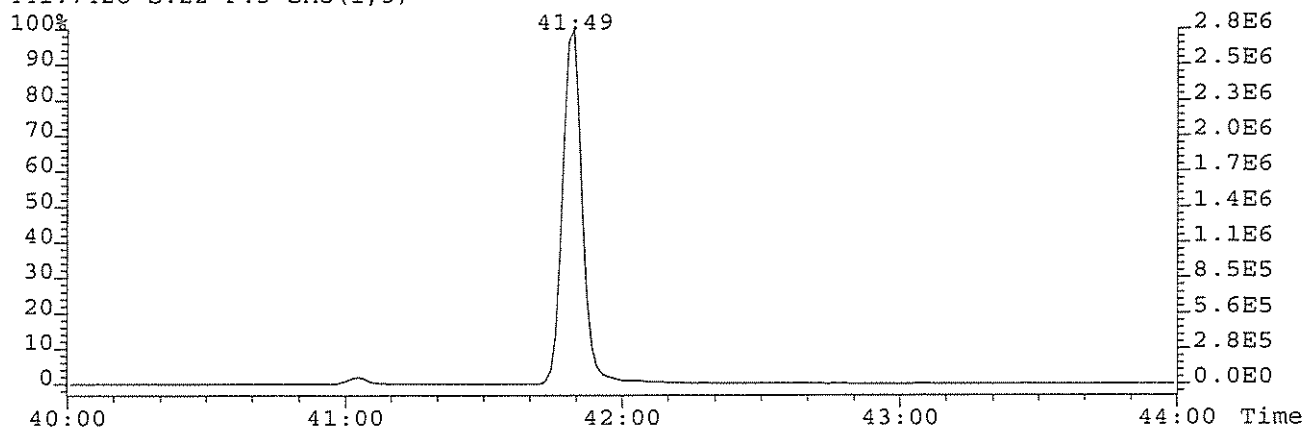
437.8140 S:22 F:3 SMO(1,3)



PCDDsクロマトグラム (10)  
(HpCDDs)

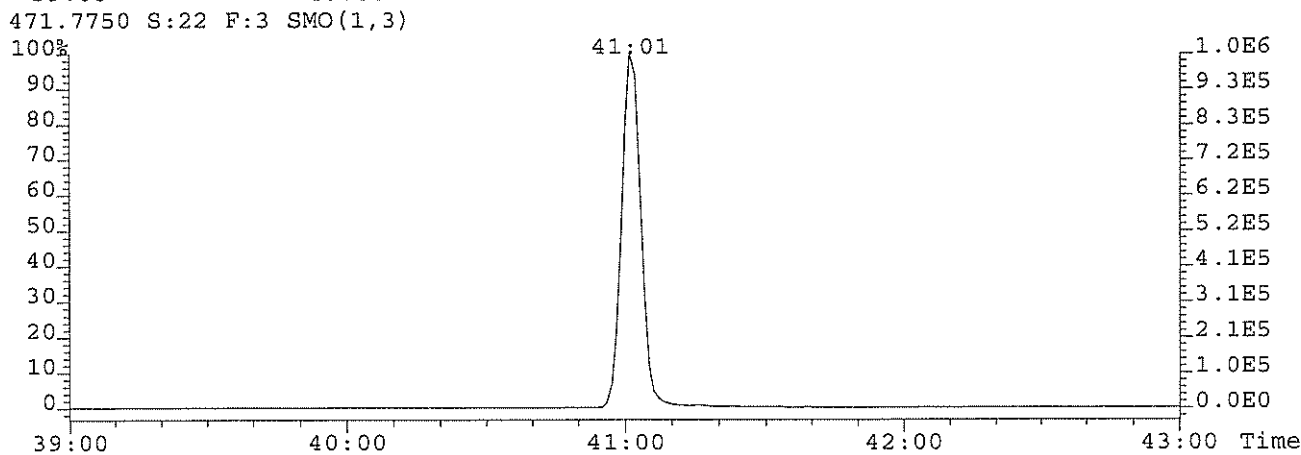
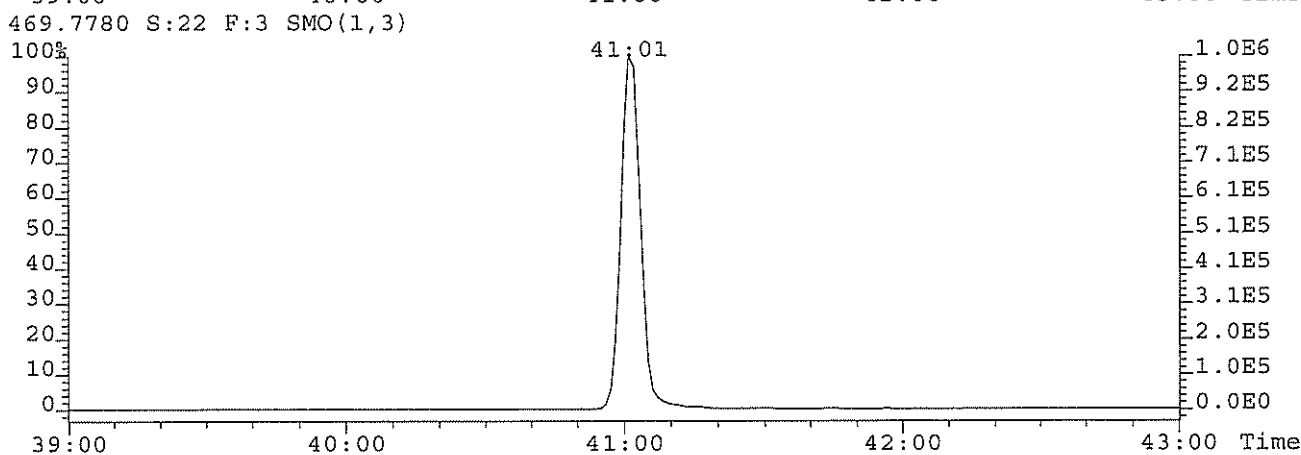
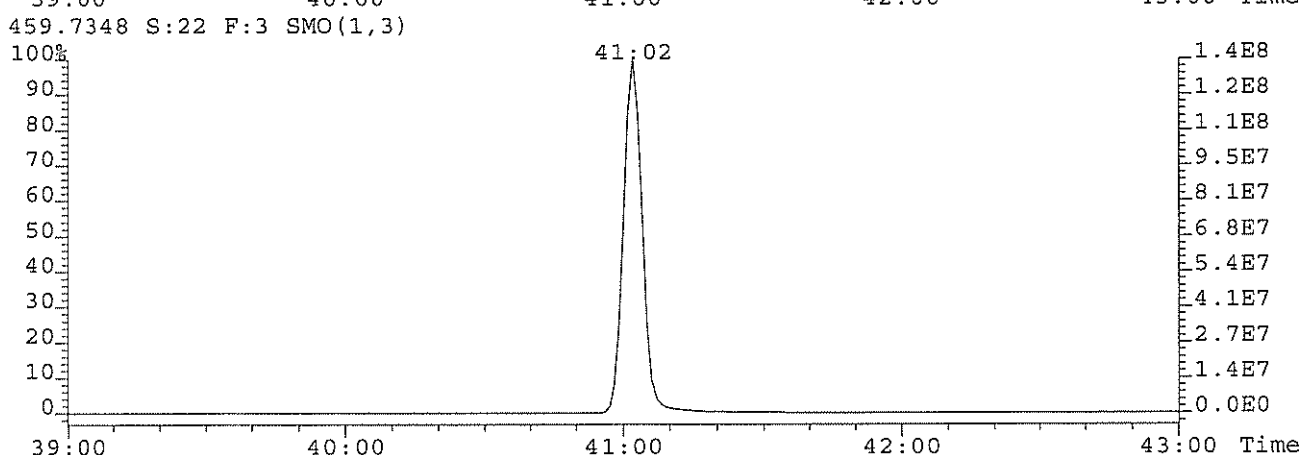
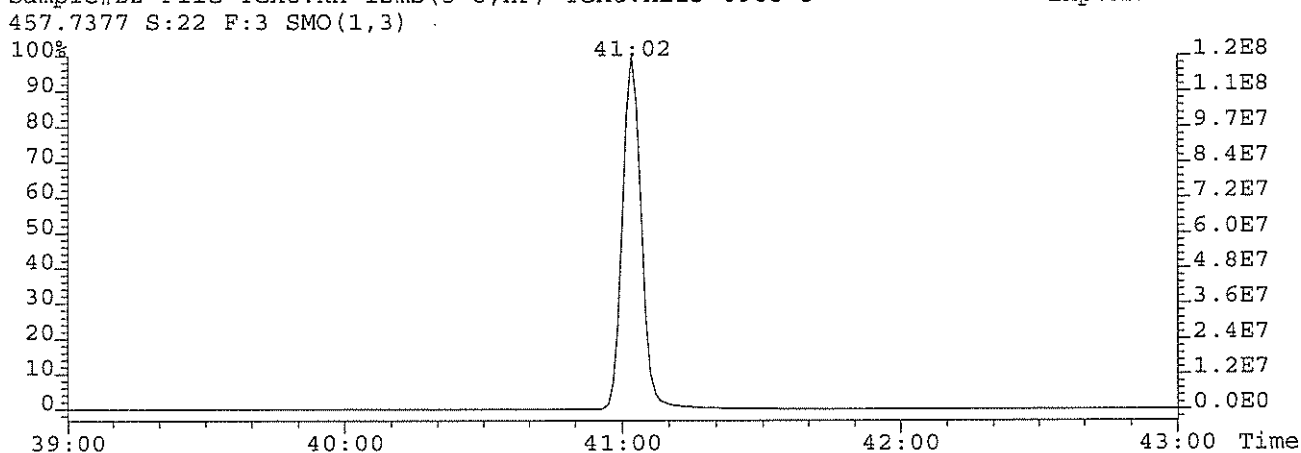


File:130713 #1-561 Acq:14-JUL-2013 05:33:45 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0968 3 Exp:RH-PD22  
441.7428 S:22 F:3 SMO(1,3)



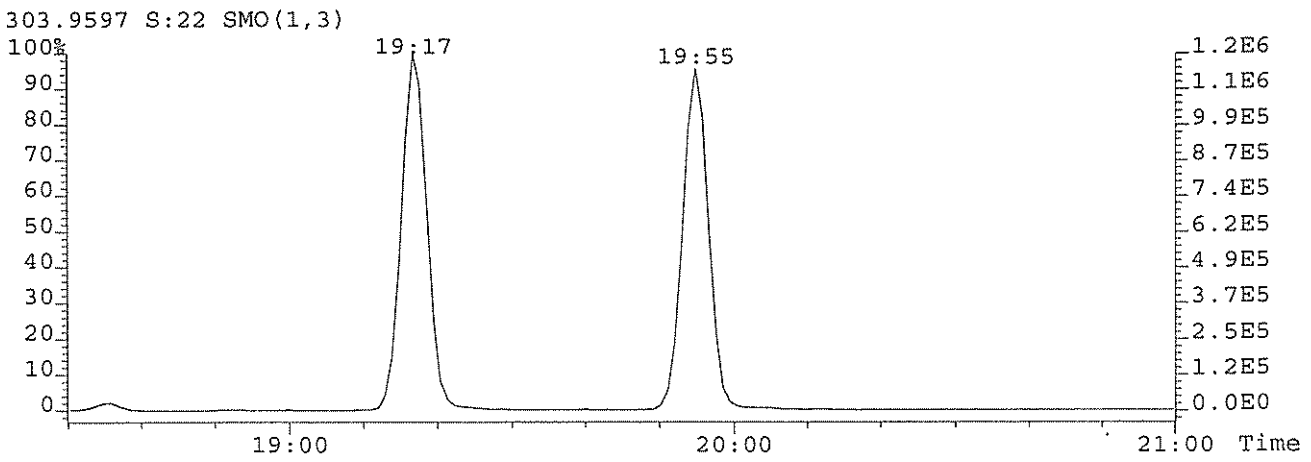
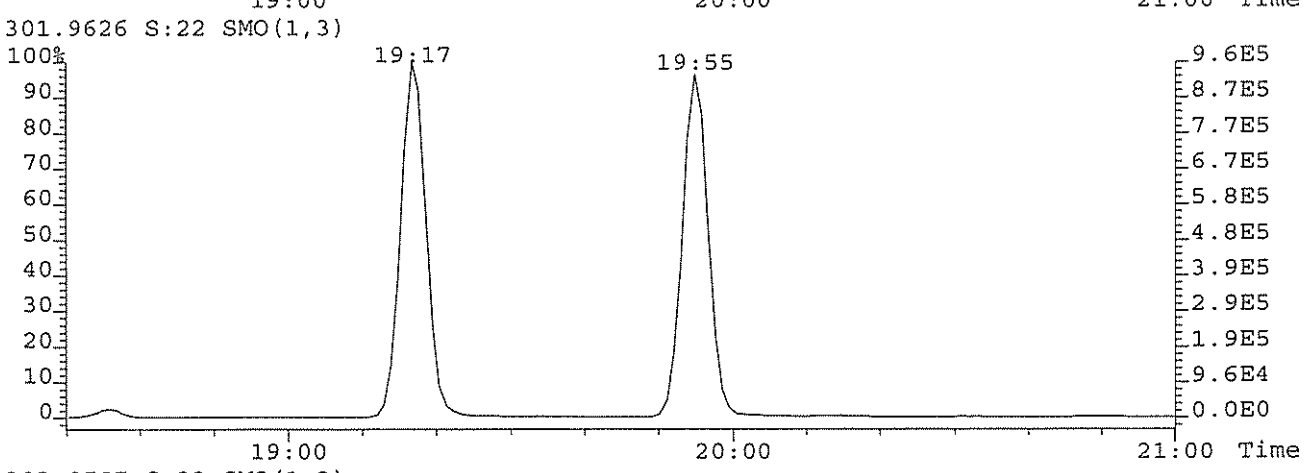
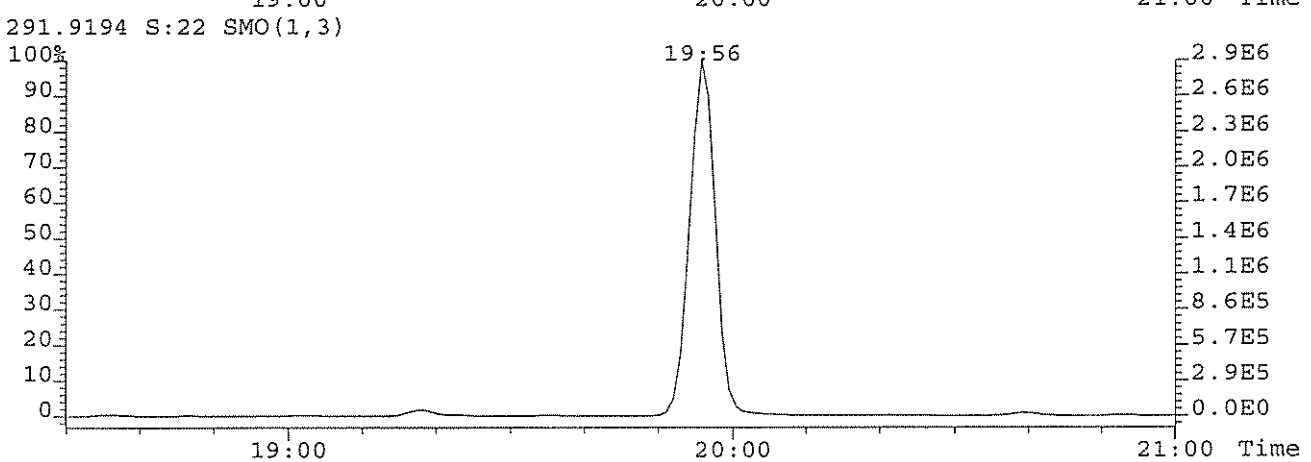
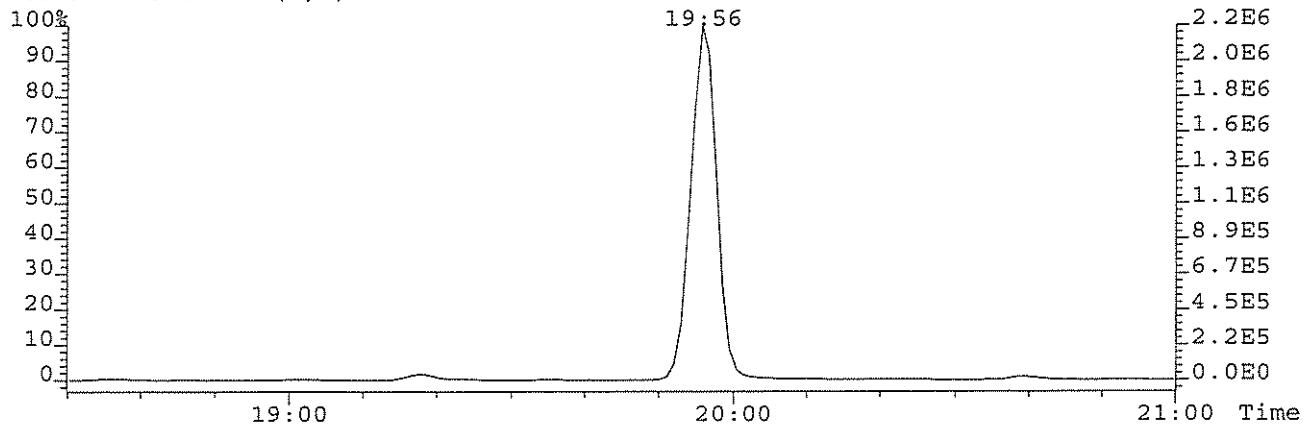
PCDFsクロマトグラム (11)  
(OCDF)

File:130713 #1-561 Acq:14-JUL-2013 05:33:45 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0968 3 Exp:RH-PD22



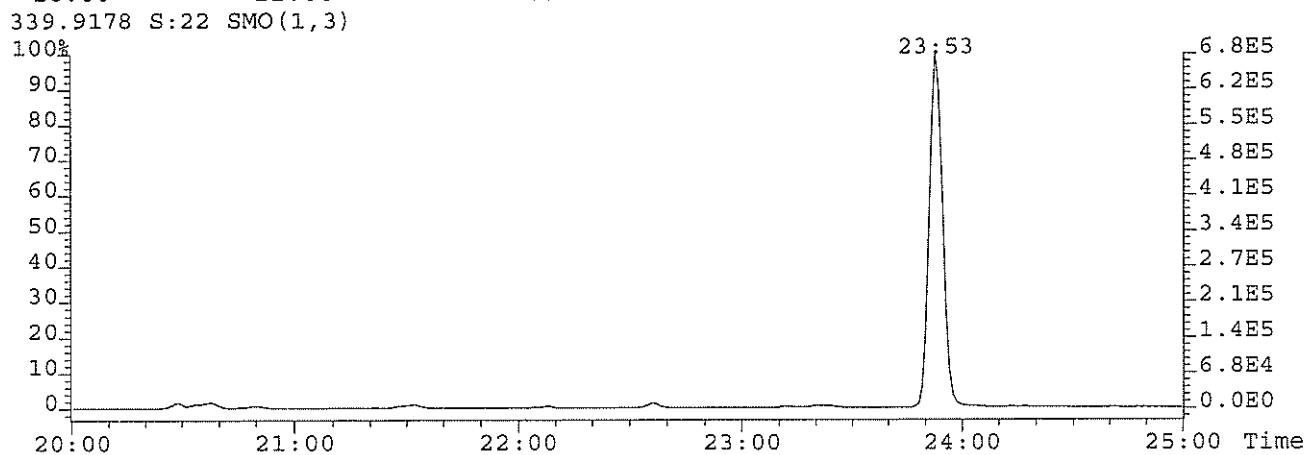
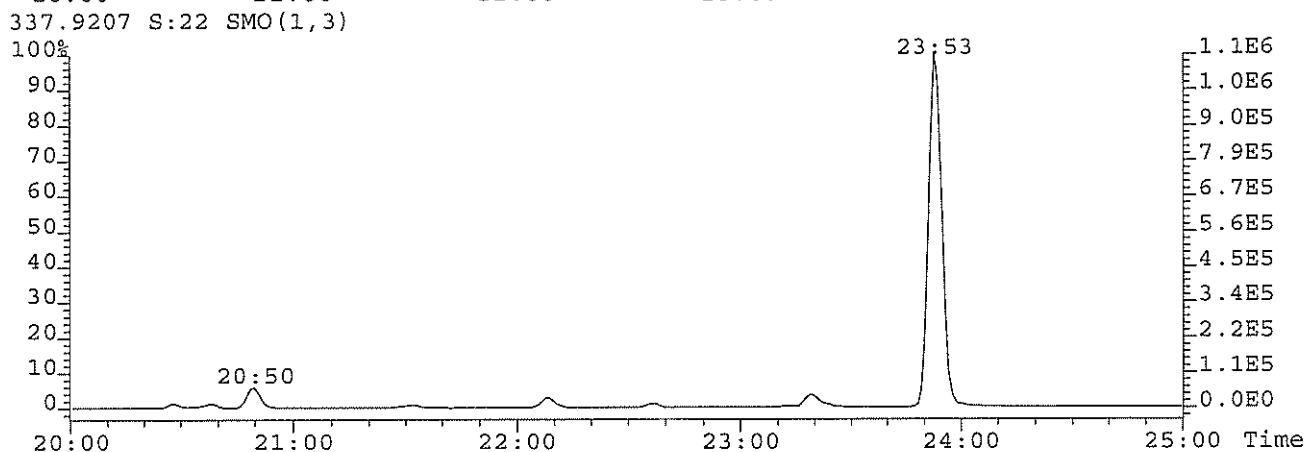
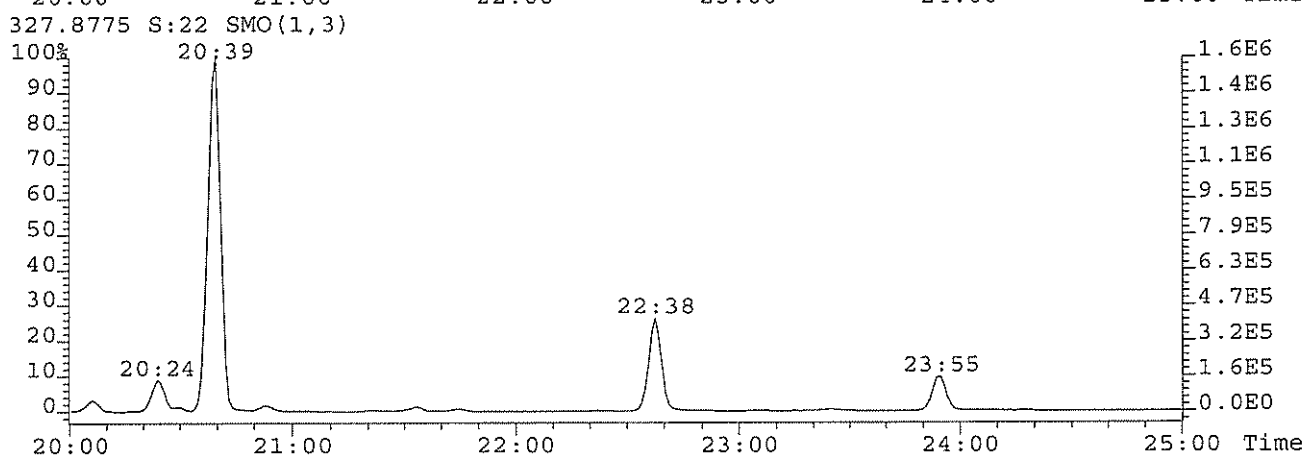
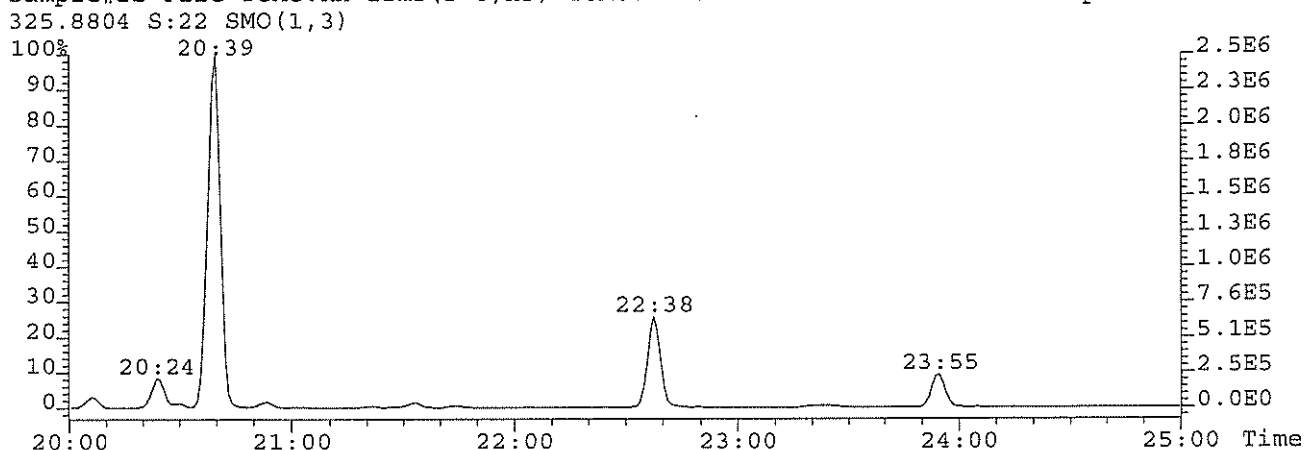
PCDDsクロマトグラム (12)  
(OCDD)

File:130713 #1-1430 Acq:14-JUL-2013 05:33:45 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0968 3 Exp:RH-PD22  
289.9224 S:22 SMO(1,3)



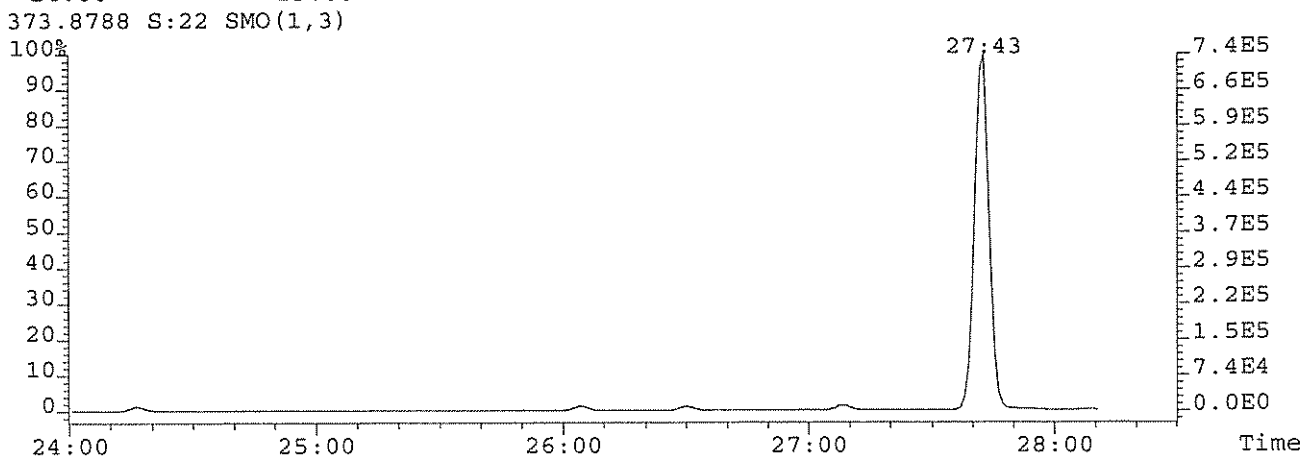
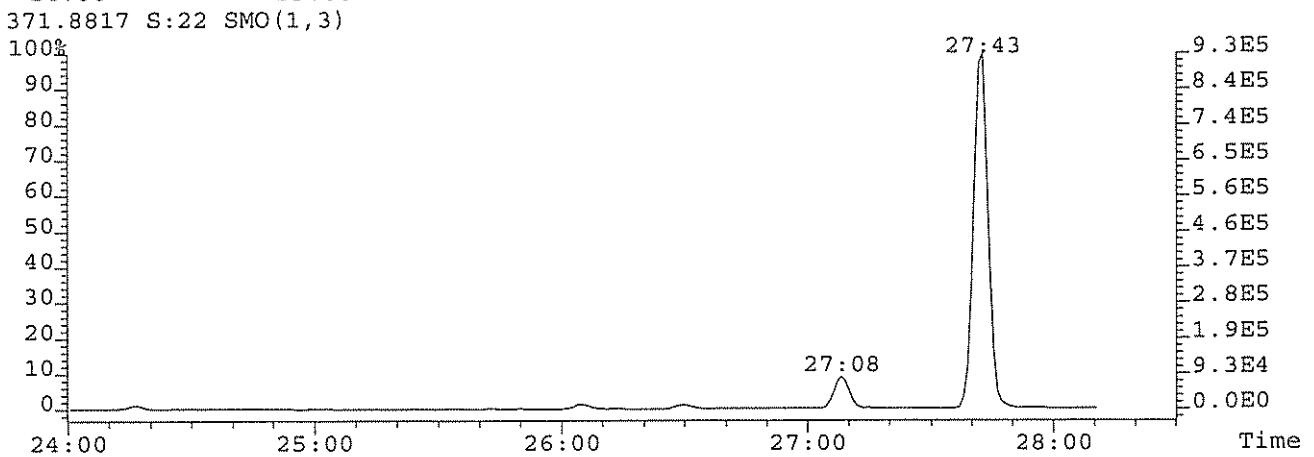
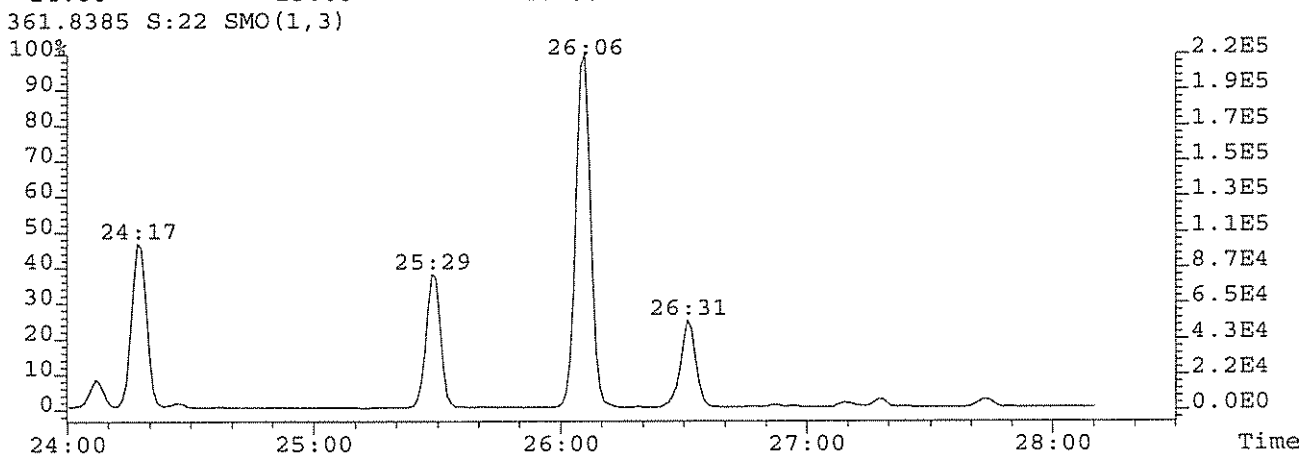
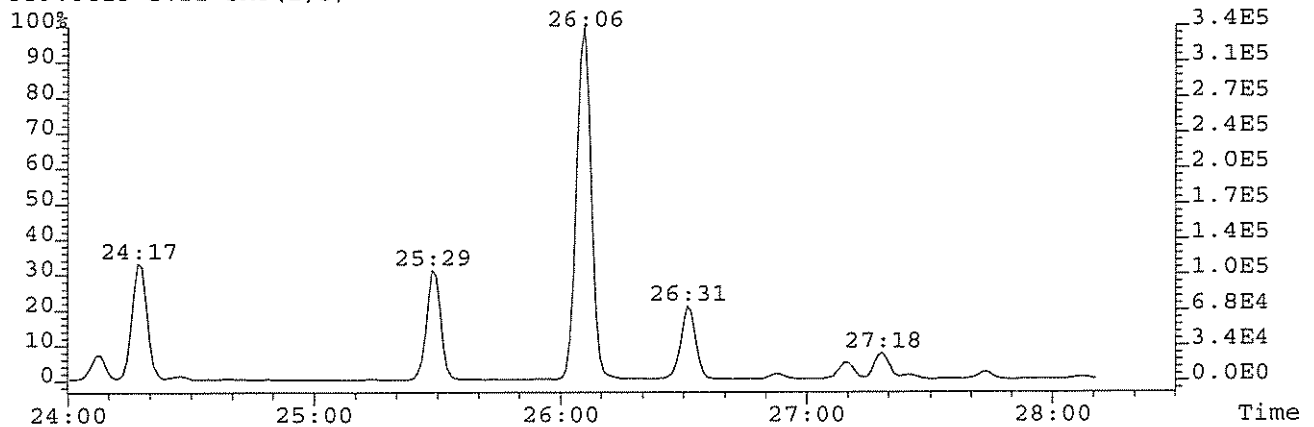
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130713 #1-1430 Acq:14-JUL-2013 05:33:45 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0968 3 Exp:RH-PD22



DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

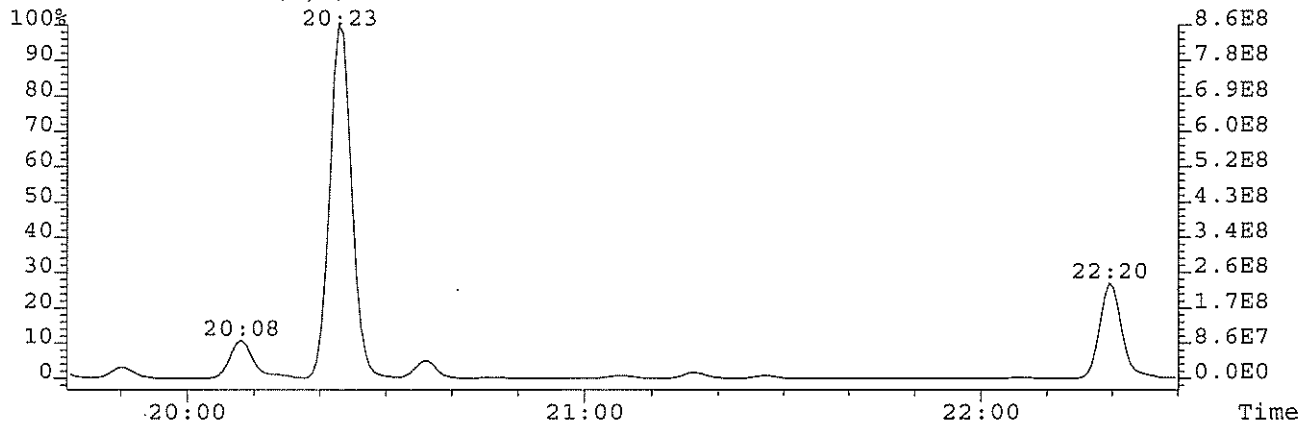
File:130713 #1-1430 Acq:14-JUL-2013 05:33:45 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#22 File Text:RH-12ms(5-8,nP) Text:XE13 0968 3 Exp:RH-PD22  
359.8415 S:22 SMO(1,3)



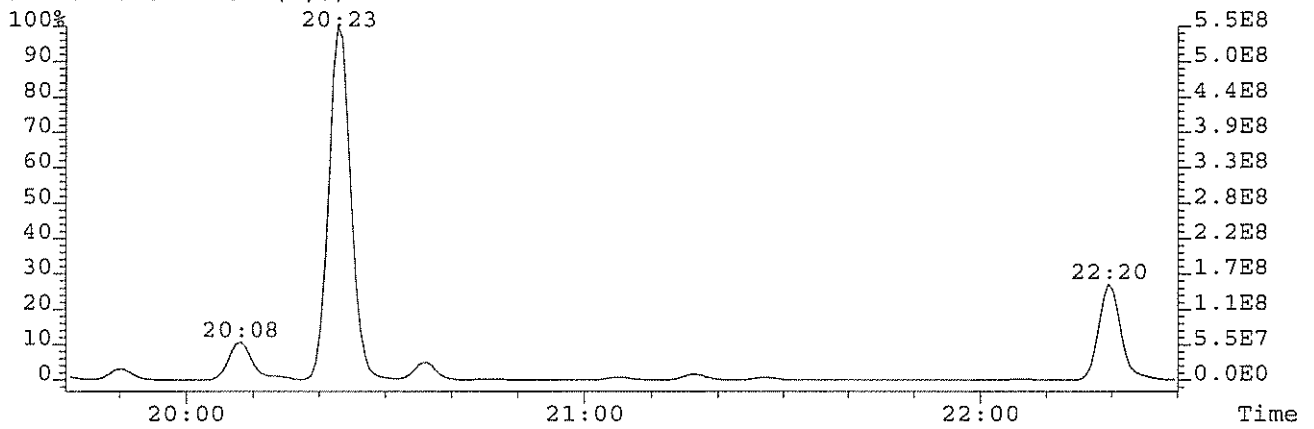
DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

File:130713 #1-2898 Acq:14-JUL-2013 02:01:53 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(mP) Text:XE13 0968 2 Exp:RH-MP11

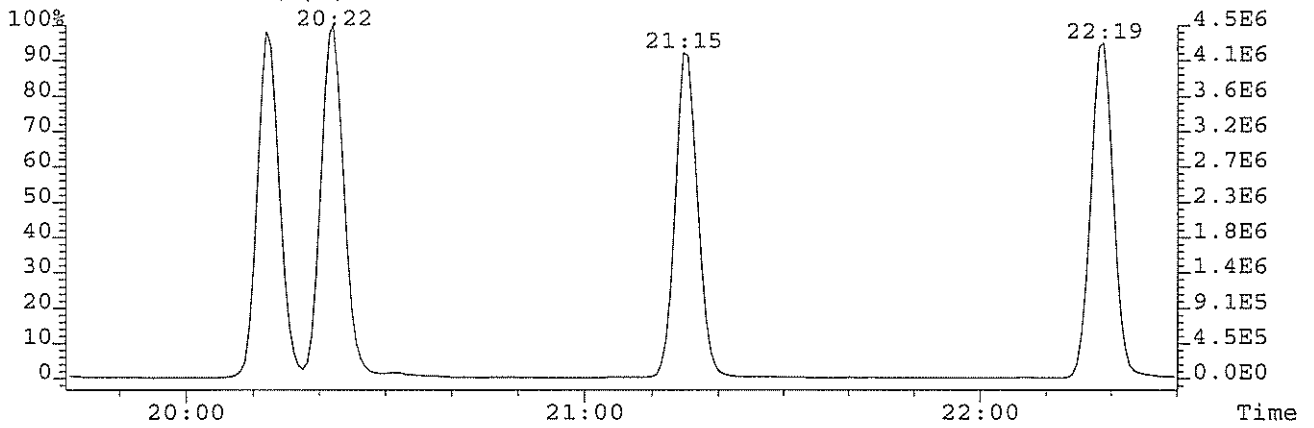
325.8804 S:21 SMO(1,3)



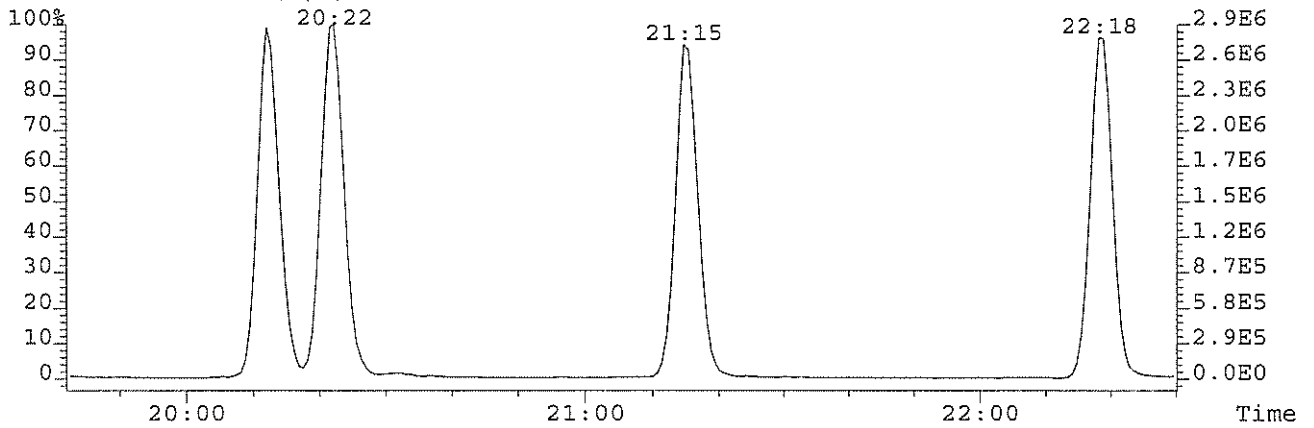
327.8775 S:21 SMO(1,3)



337.9207 S:21 SMO(1,3)

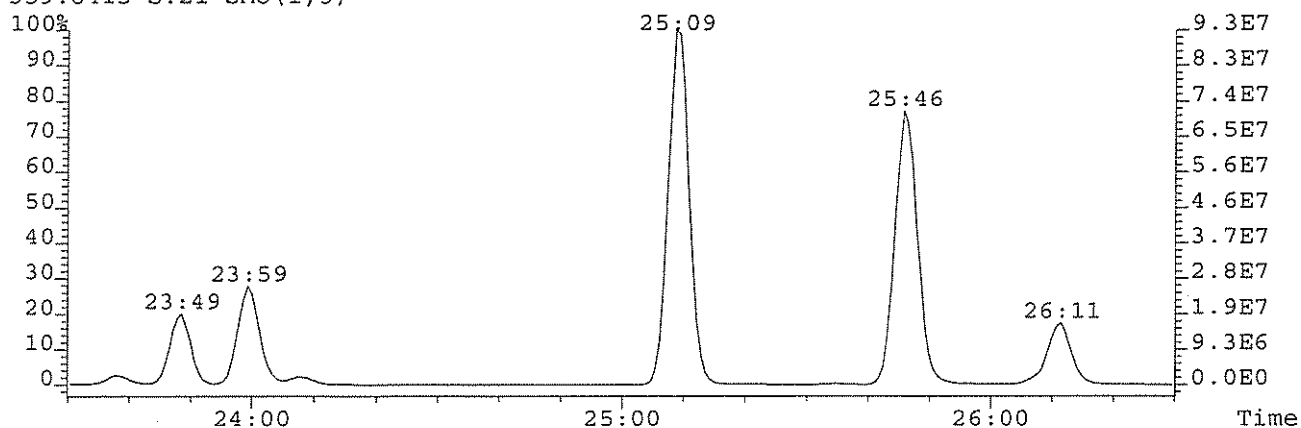


339.9178 S:21 SMO(1,3)

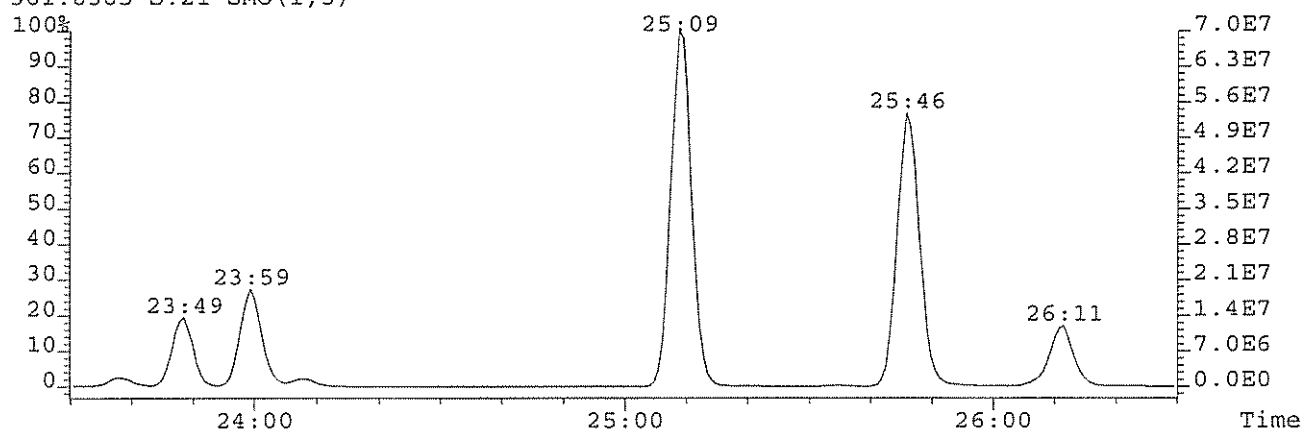


DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

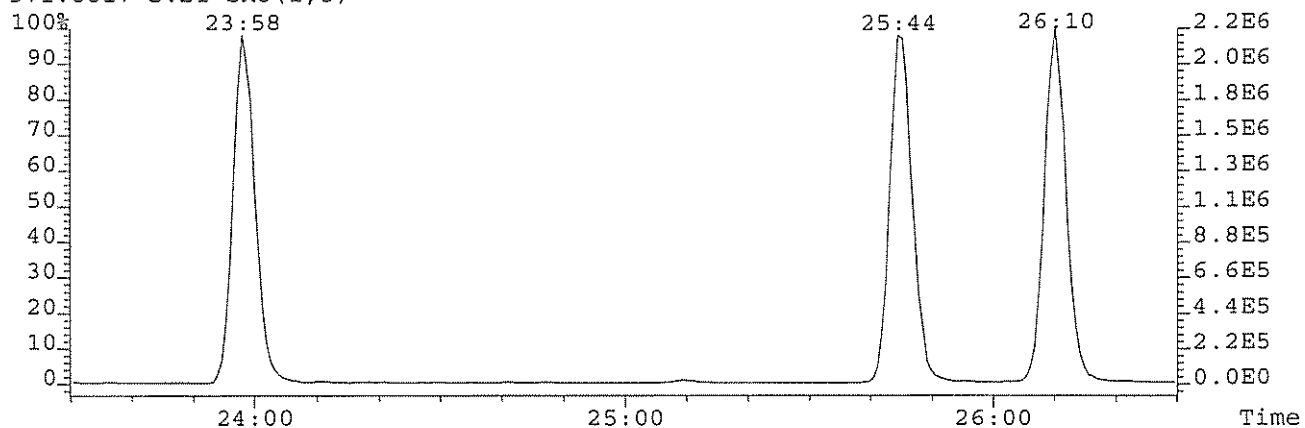
File:130713 #1-2898 Acq:14-JUL-2013 02:01:53 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(mP) Text:XE13 0968 2 Exp:RH-MP11  
359.8415 S:21 SMO(1,3)



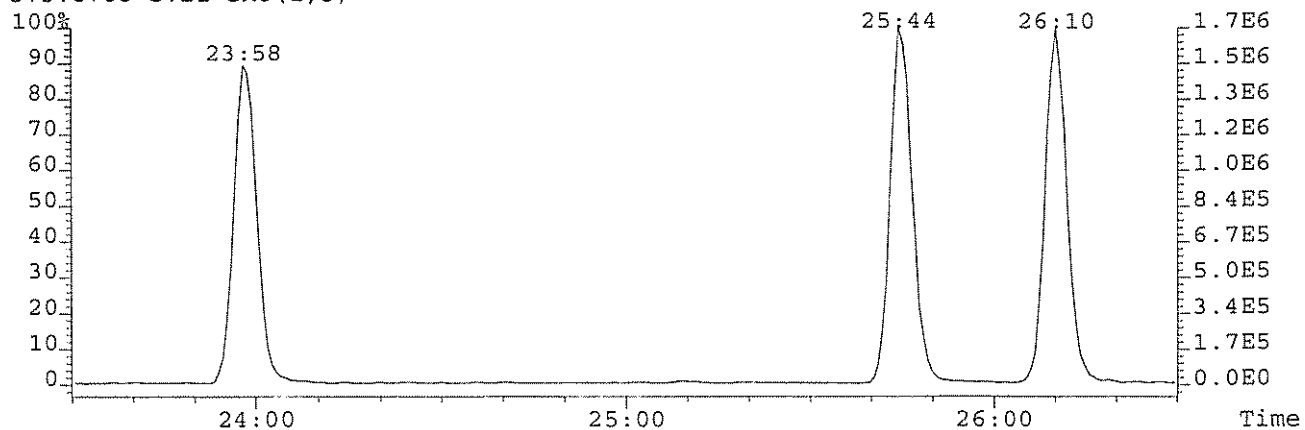
361.8385 S:21 SMO(1,3)



371.8817 S:21 SMO(1,3)

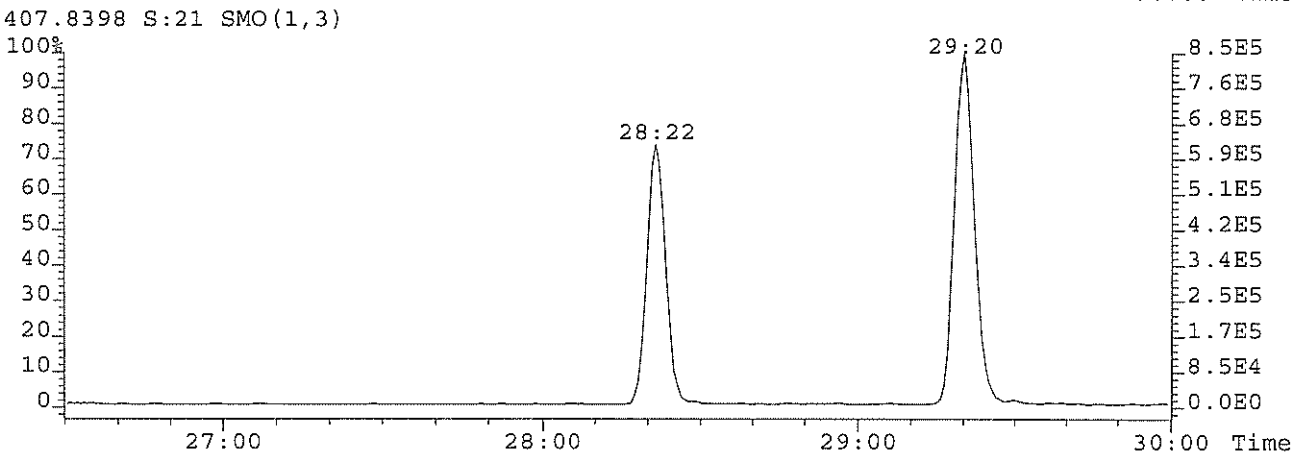
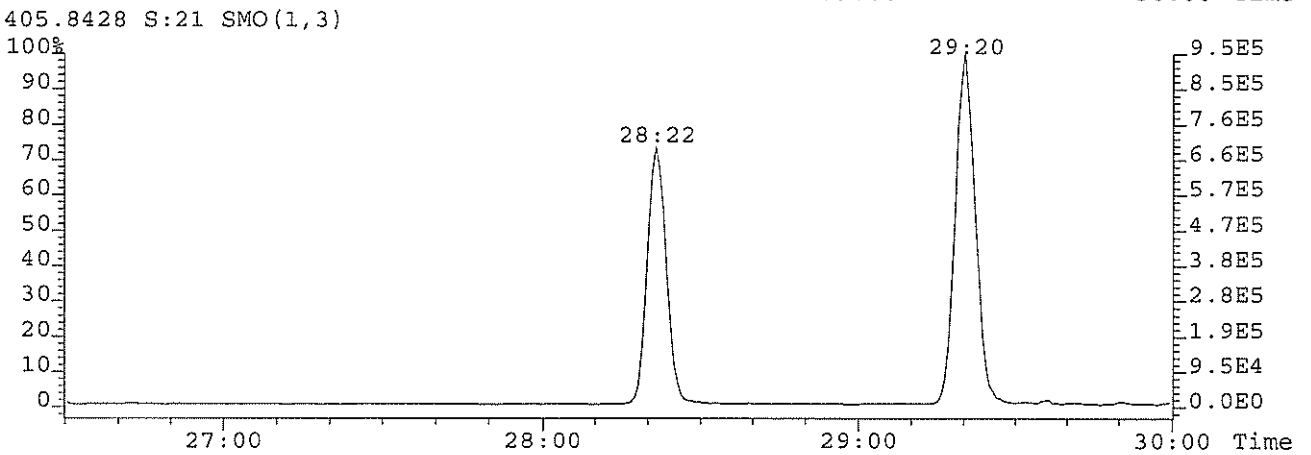
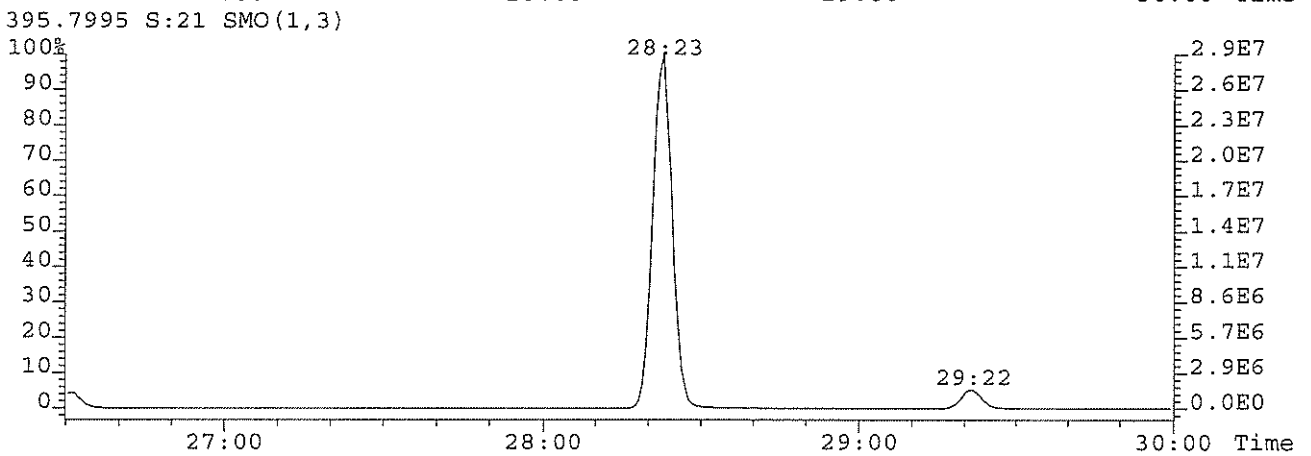
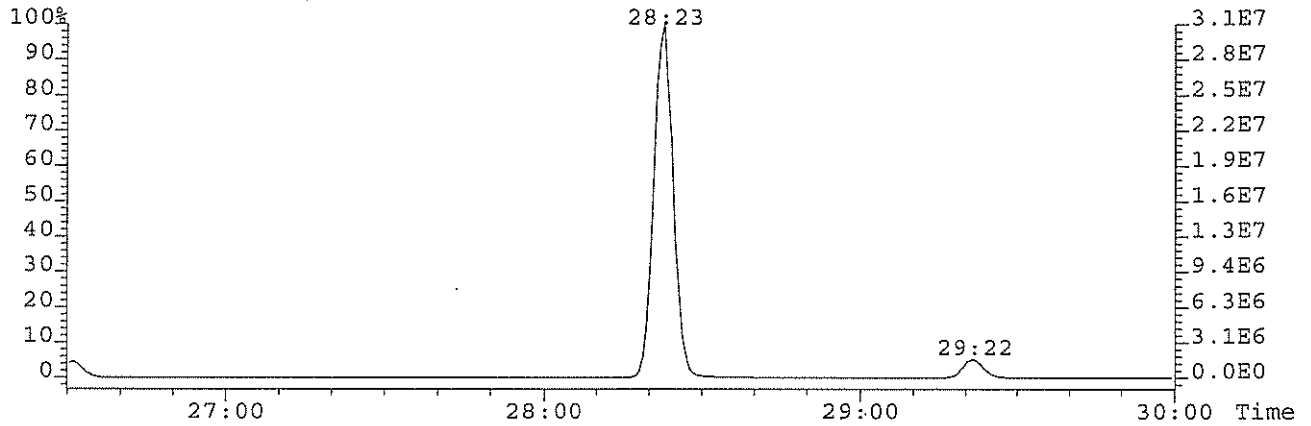


373.8788 S:21 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130713 #1-2898 Acq:14-JUL-2013 02:01:53 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#21 File Text:RH-12ms(mP) Text:XE13 0968 2 Exp:RH-MP11  
393.8025 S:21 SMO(1,3)

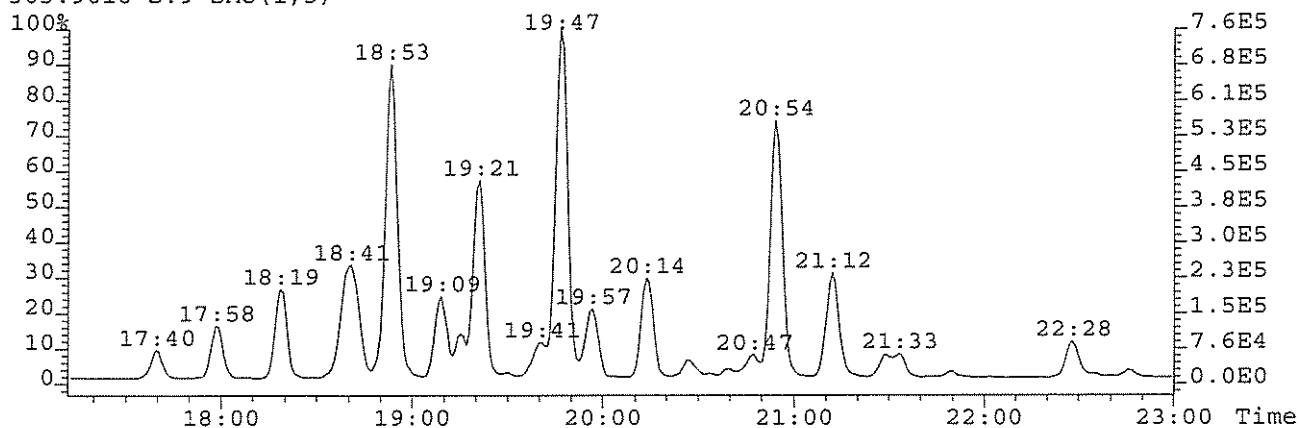


DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)

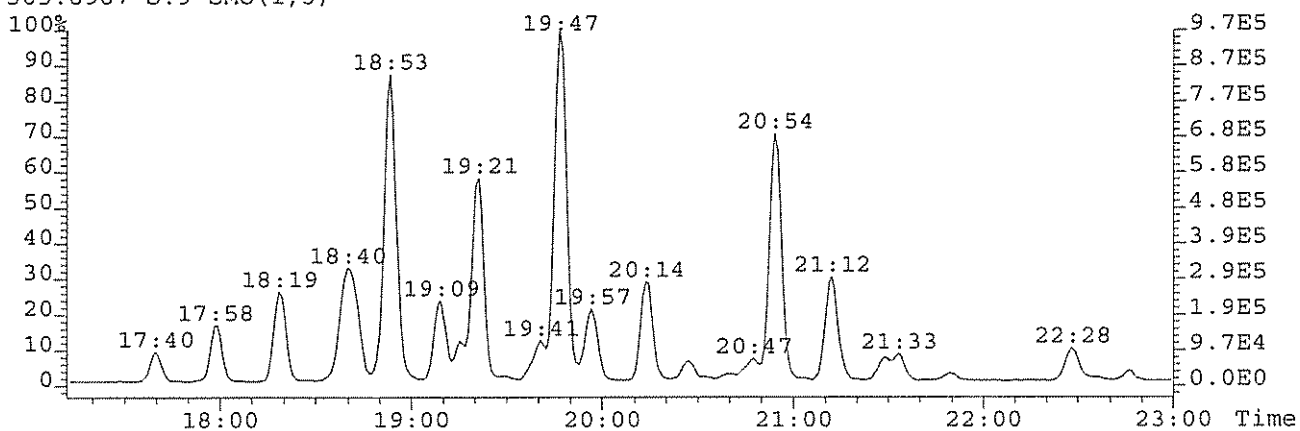


試料管理番号	XB 130969
採取場所	旧嘉手納飛行場
試料名	ドラム缶付着物(水)

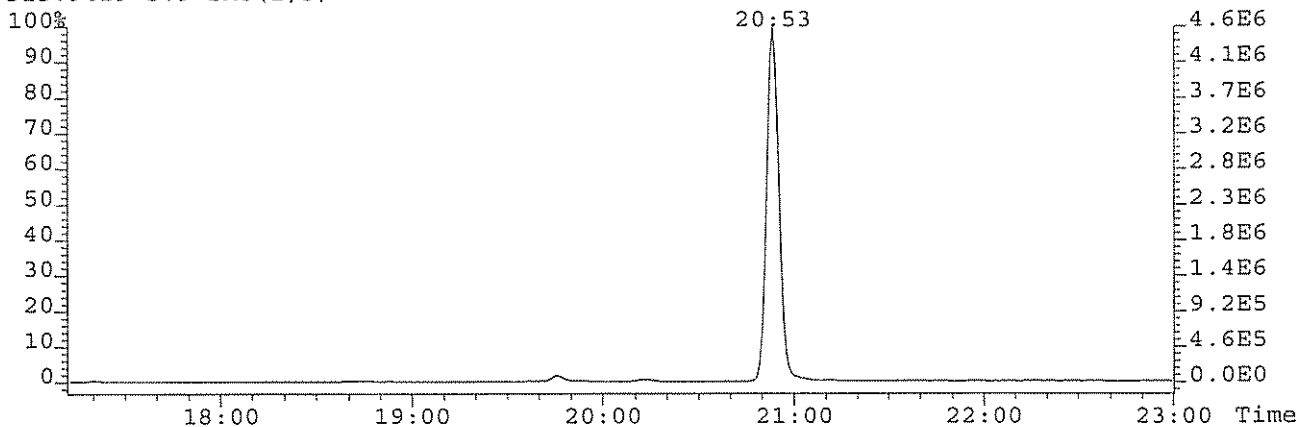
File:130712-2 #1-1577 Acq:12-JUL-2013 23:12:32 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#9 File Text:BPX-DXN(4-6DXN) Text:XB13 0969 Exp:BPX04  
303.9016 S:9 SMO(1,3)



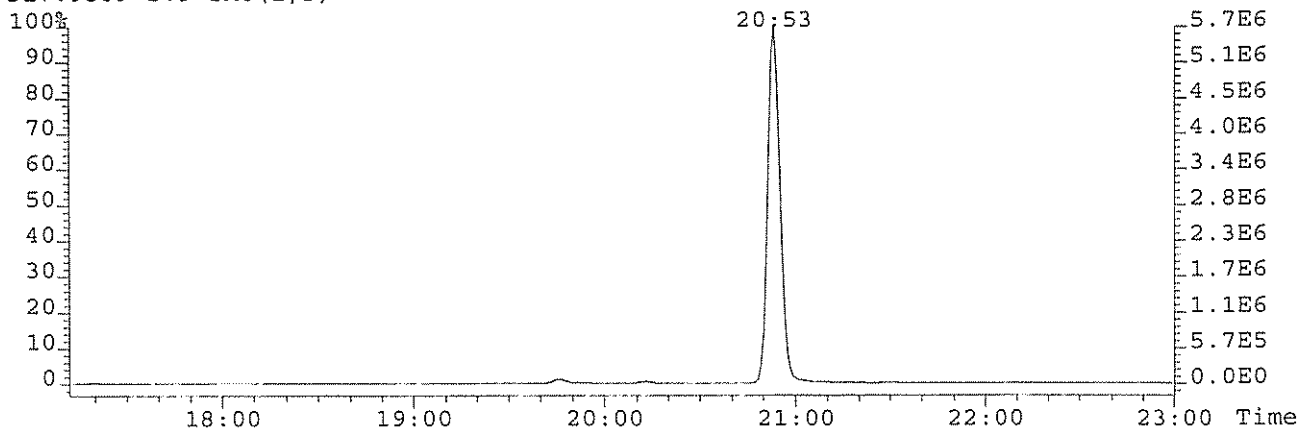
305.8987 S:9 SMO(1,3)



315.9419 S:9 SMO(1,3)

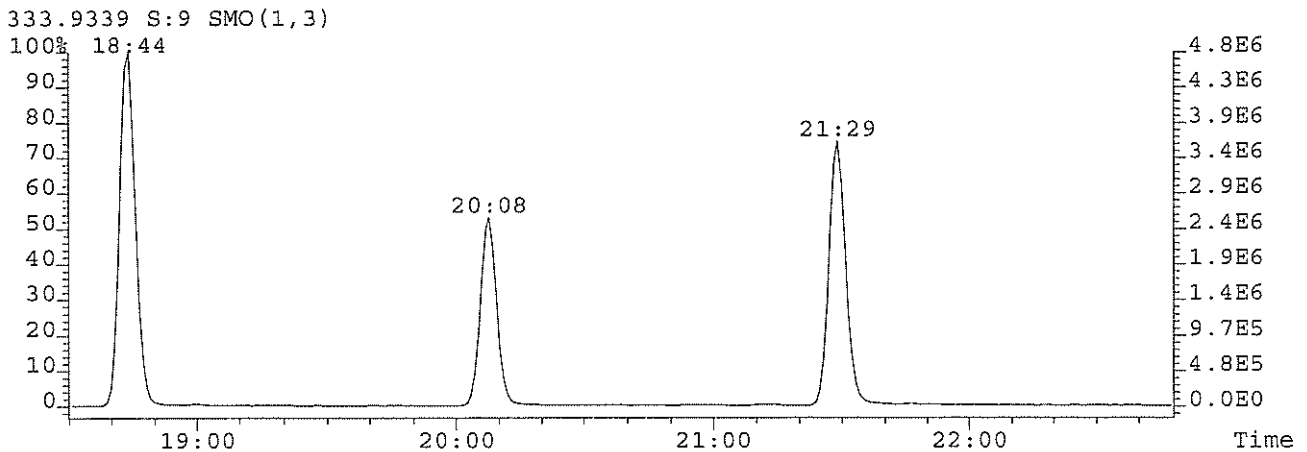
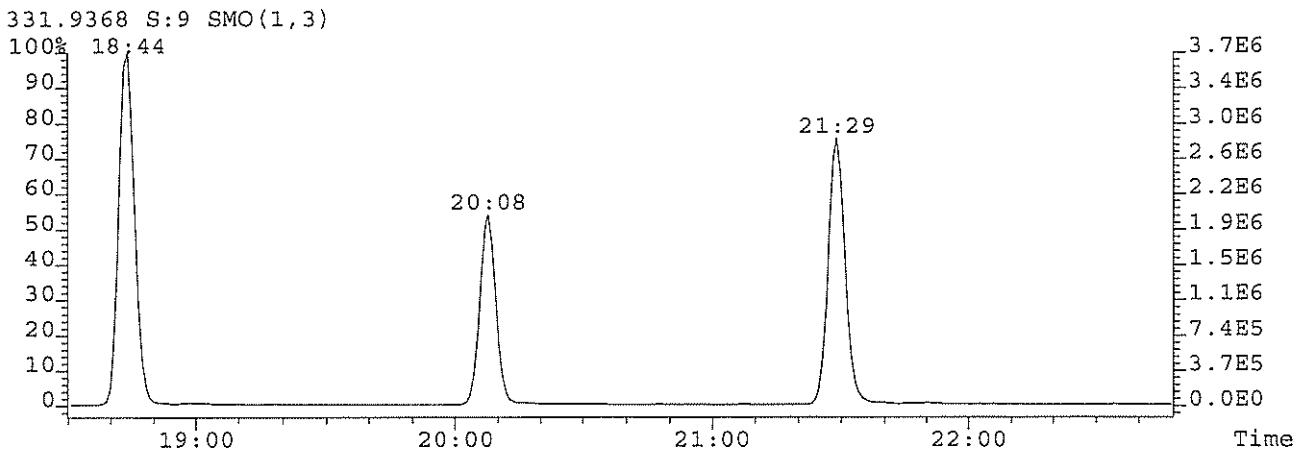
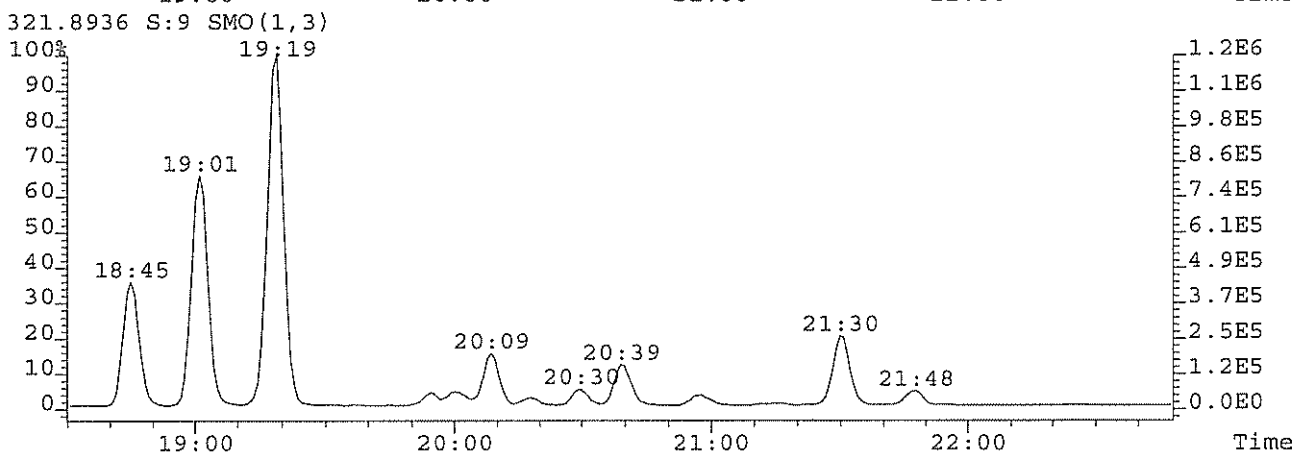
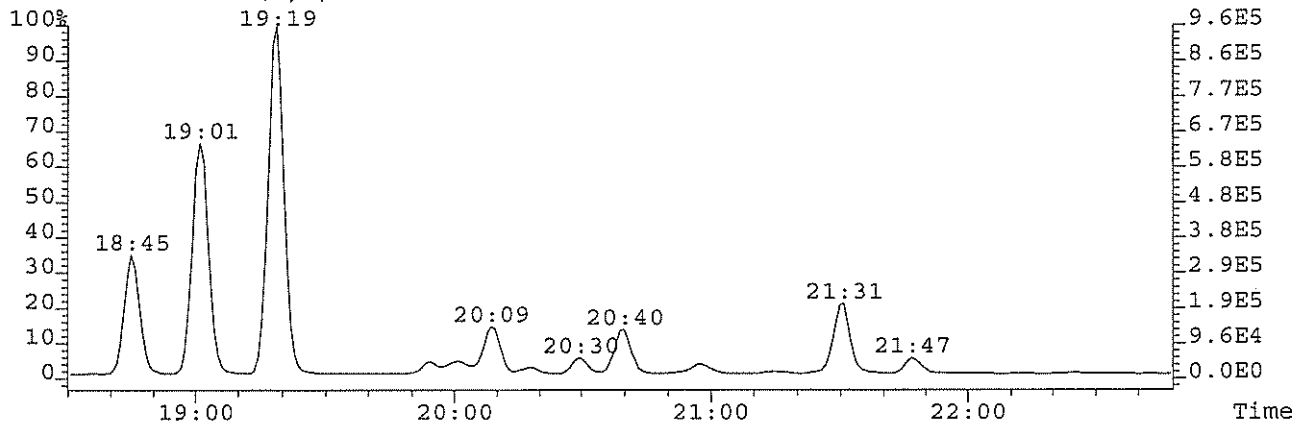


317.9389 S:9 SMO(1,3)



PCDFsクロマトグラム (1)  
(TeCDFs)

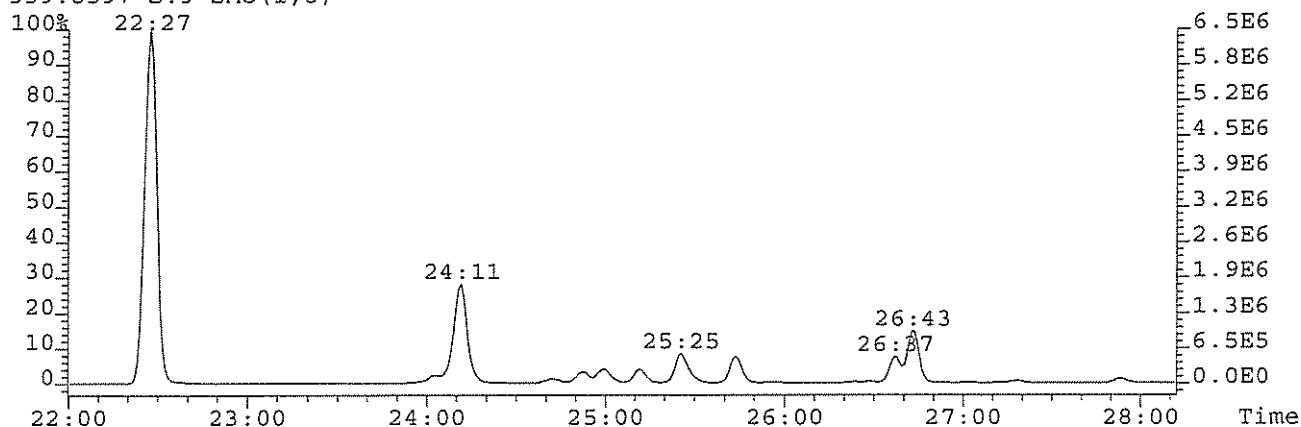
File:130712-2 #1-1577 Acq:12-JUL-2013 23:12:32 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#9 File Text:BPX-DXN(4-6DXN) Text:XB13 0969 Exp:BPX04  
319.8965 S:9 SMO(1,3)



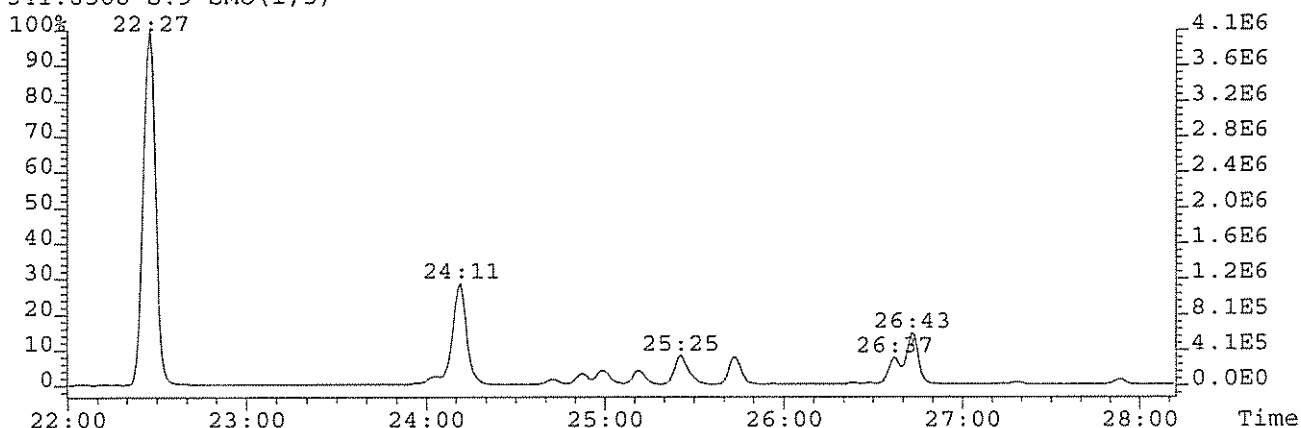
PCDDsクロマトグラム (2)  
(TeCDDs)

File:130712-2 #1-1577 Acq:12-JUL-2013 23:12:32 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#9 File Text:BPX-DXN(4-6DXN) Text:XB13 0969 Exp:BPX04

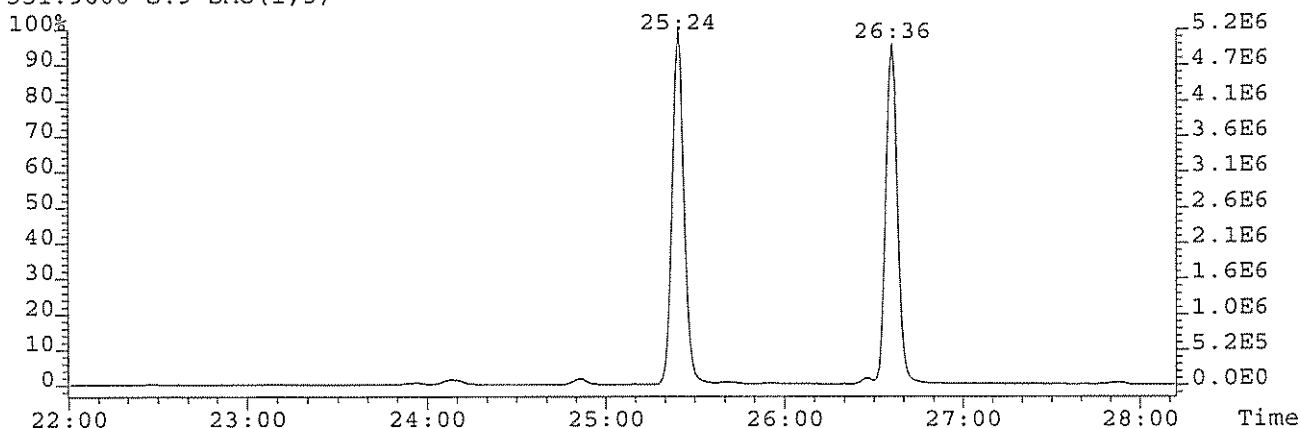
339.8597 S:9 SMO(1,3)



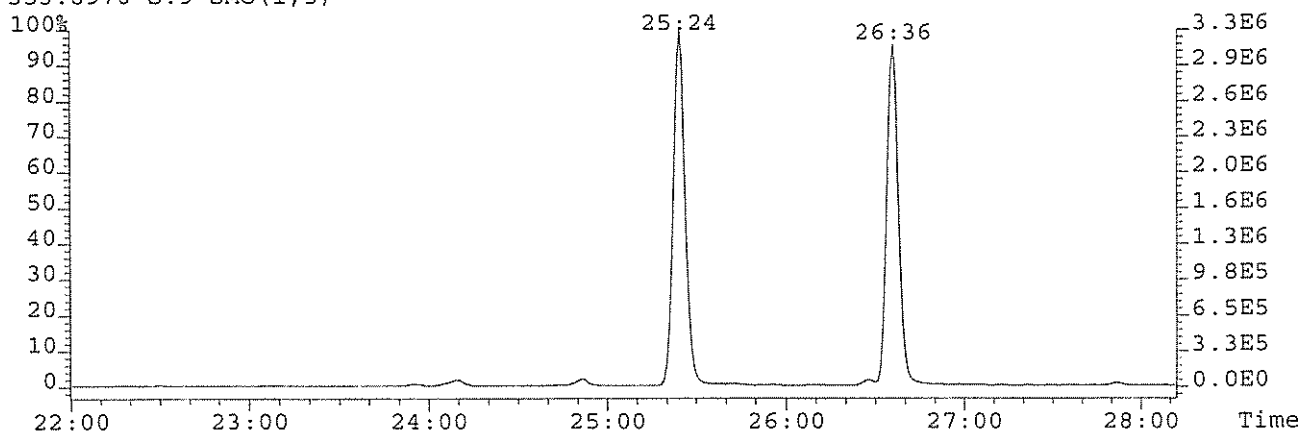
341.8568 S:9 SMO(1,3)



351.9000 S:9 SMO(1,3)

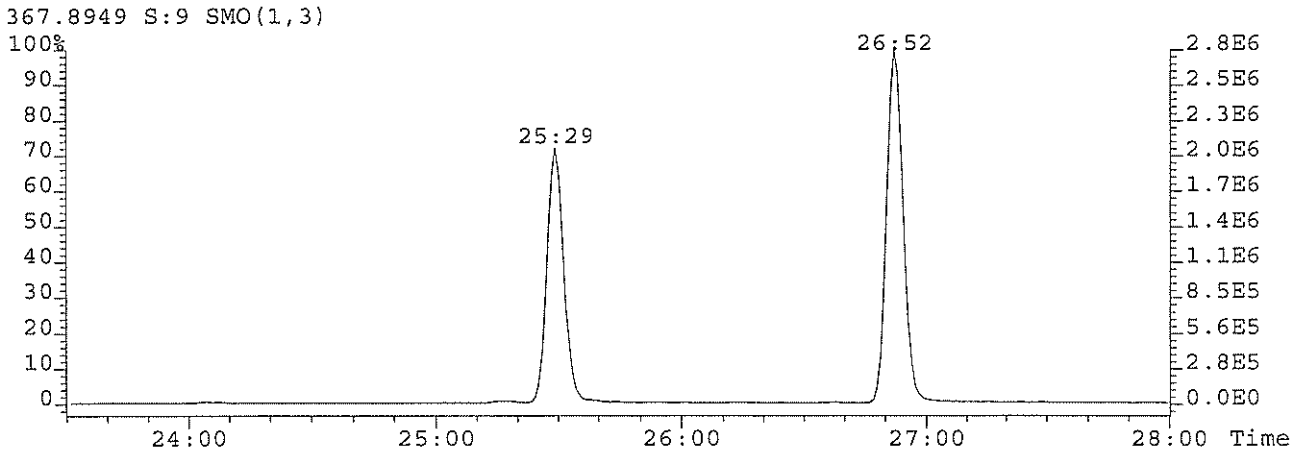
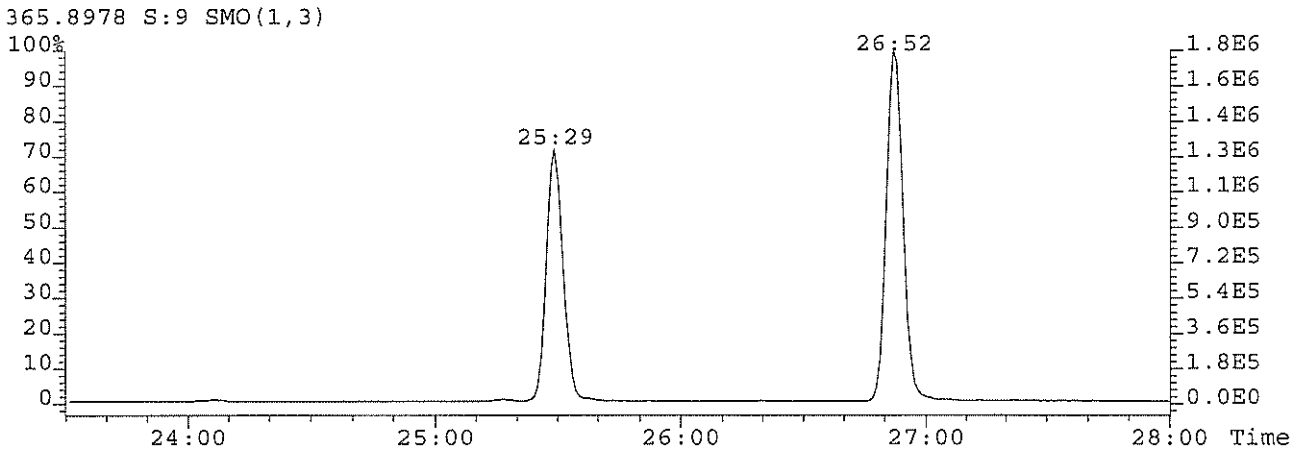
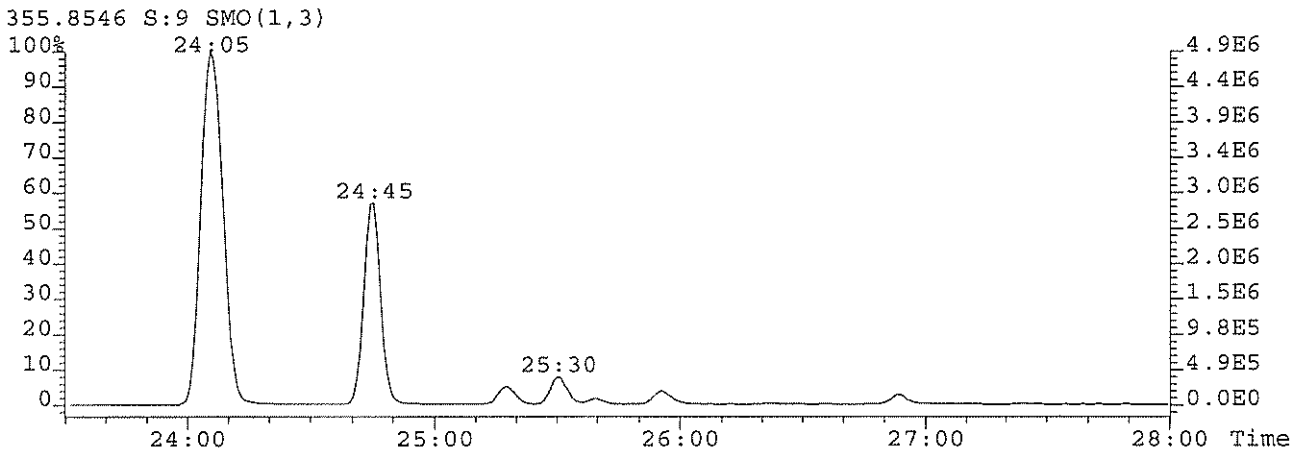
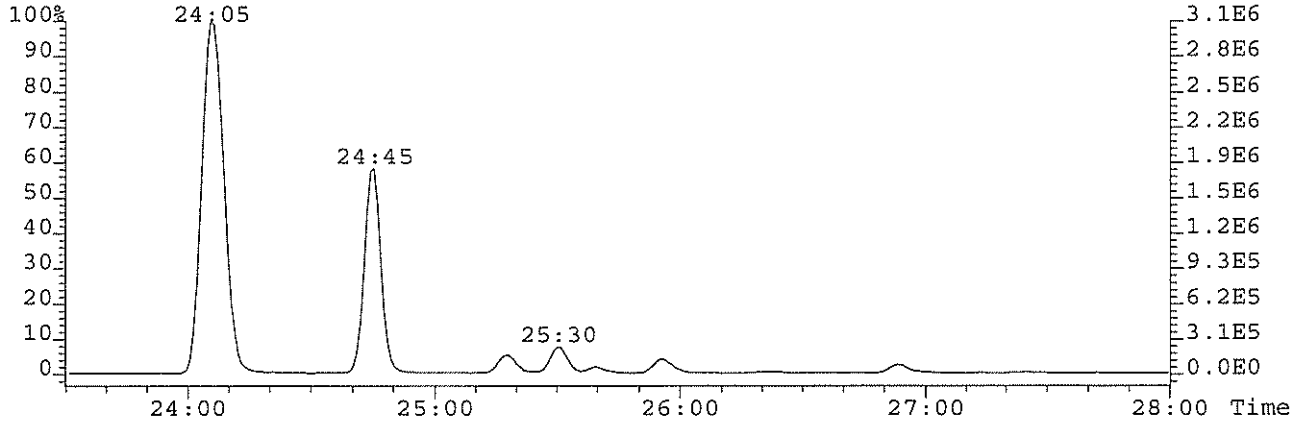


353.8970 S:9 SMO(1,3)



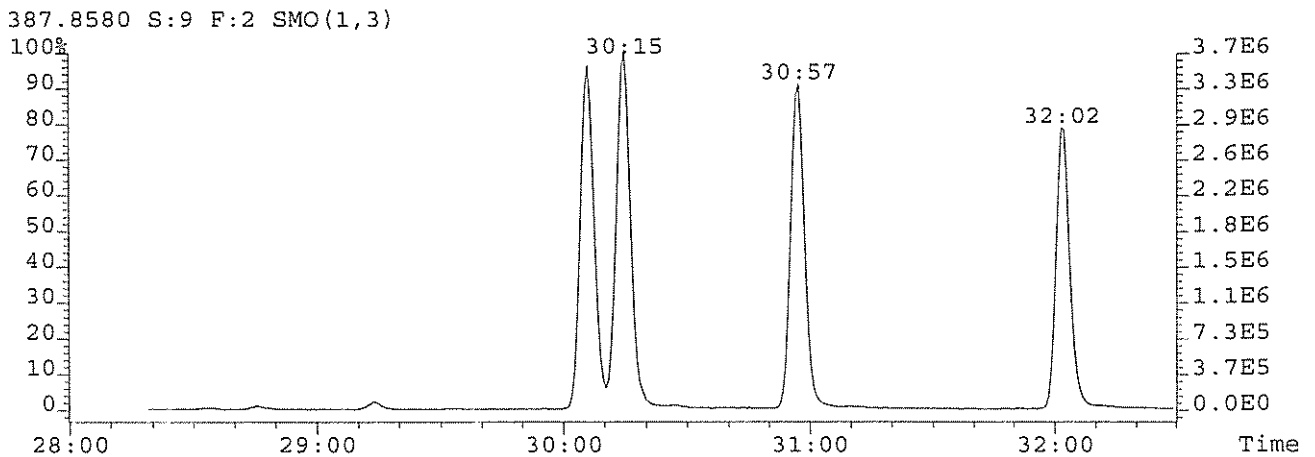
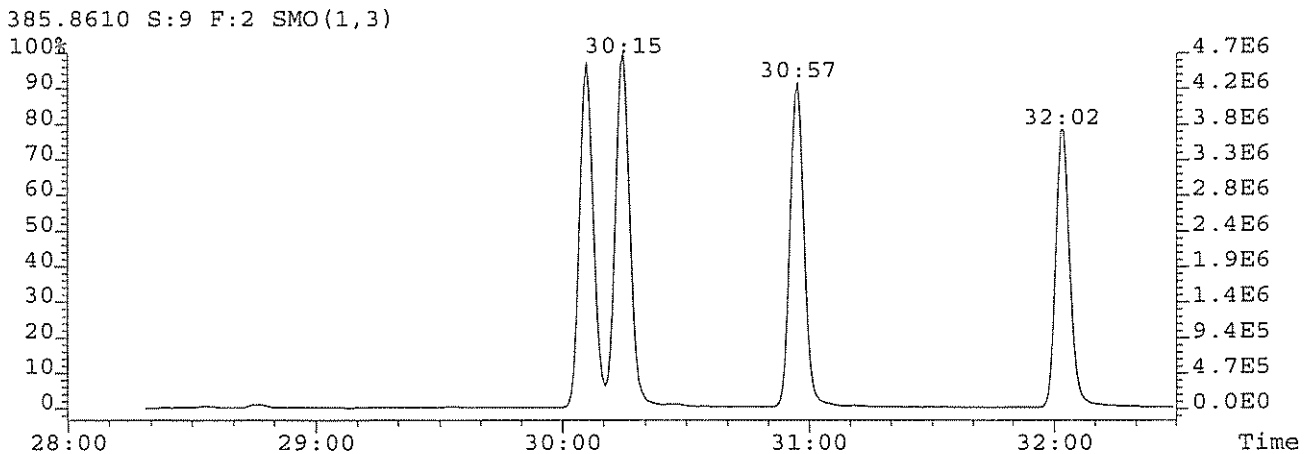
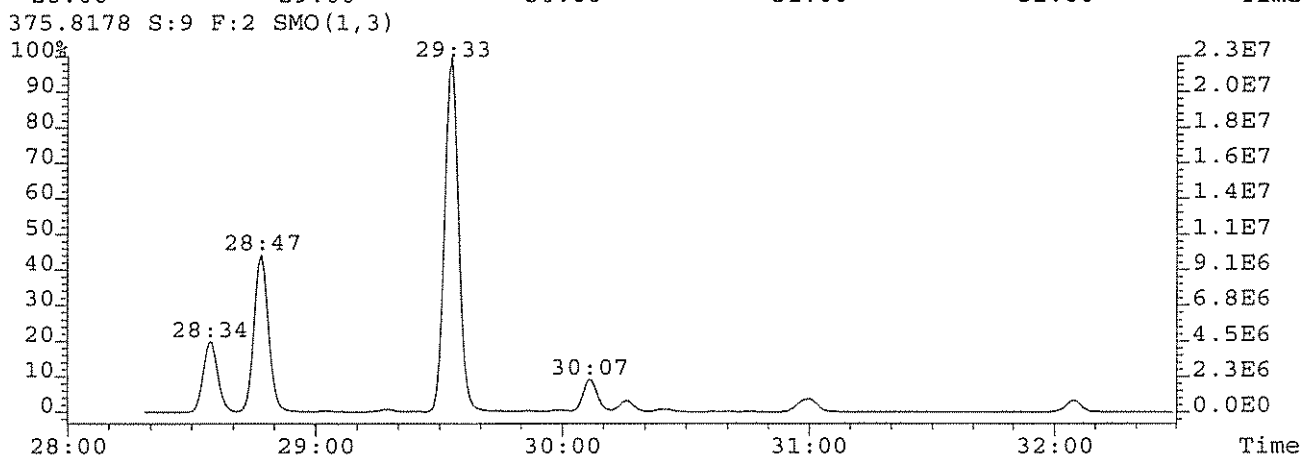
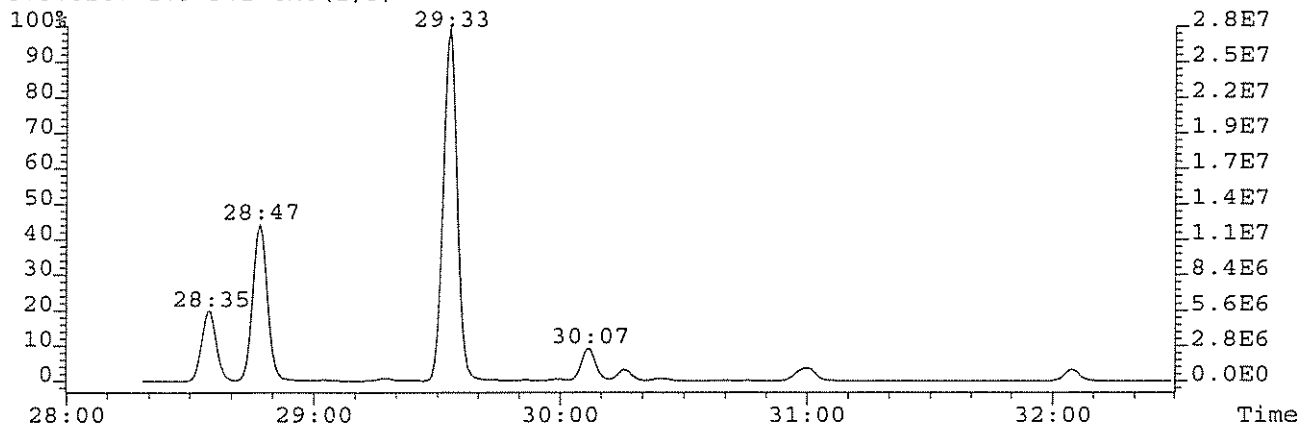
PCDFsクロマトグラム (3)  
(PeCDFs)

File:130712-2 #1-1577 Acq:12-JUL-2013 23:12:32 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#9 File Text:BPX-DXN(4-6DXN) Text:XB13 0969 Exp:BPX04  
353.8576 S:9 SMO(1,3)



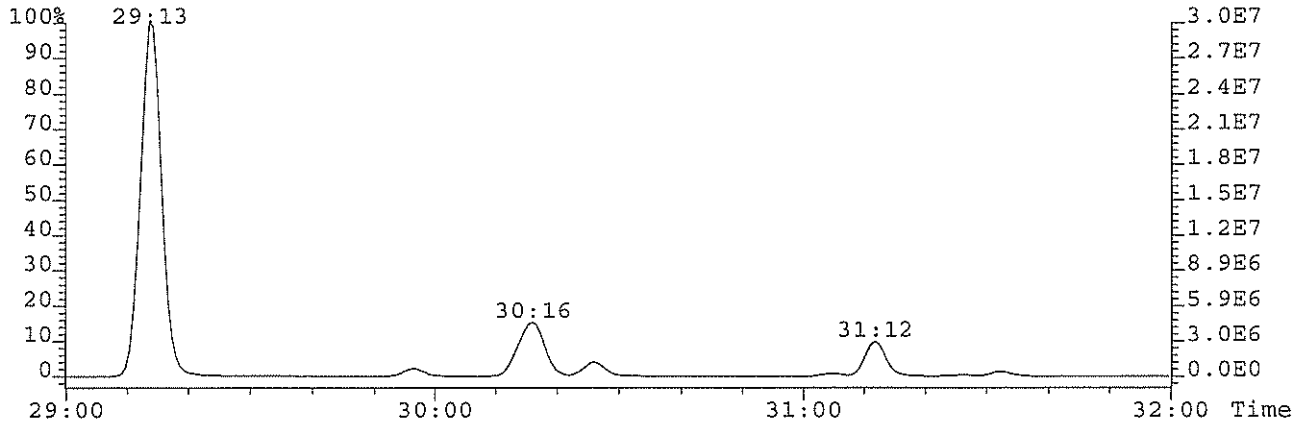
PCDDsクロマトグラム (4)  
(PeCDDs)

File:130712-2 #1-1116 Acq:12-JUL-2013 23:12:32 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#9 File Text:BPX-DXN(4-6DXN) Text:XB13 0969 Exp:BPX04  
373.8207 S:9 F:2 SMO(1,3)

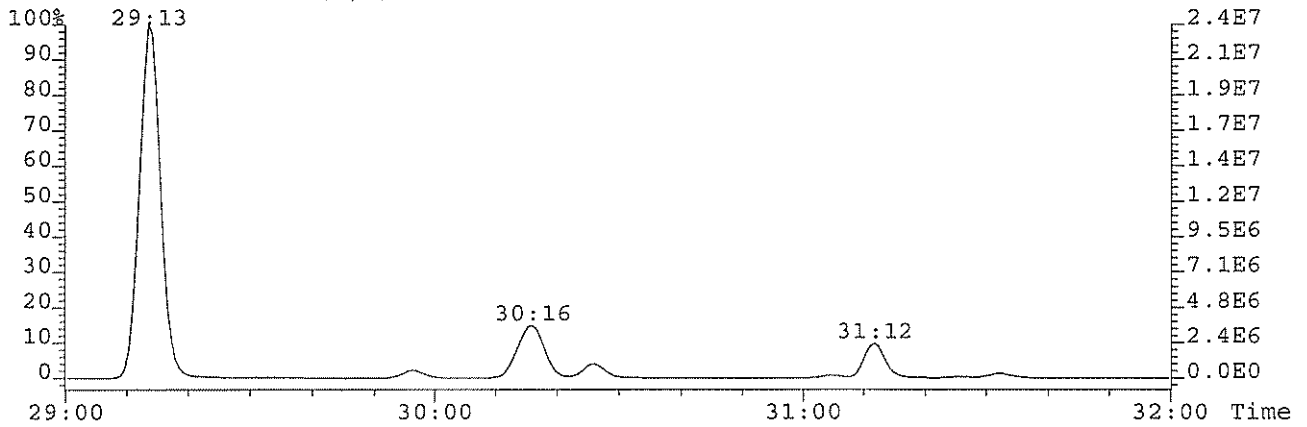


PCDFsクロマトグラム (5)  
(HxCDFs)

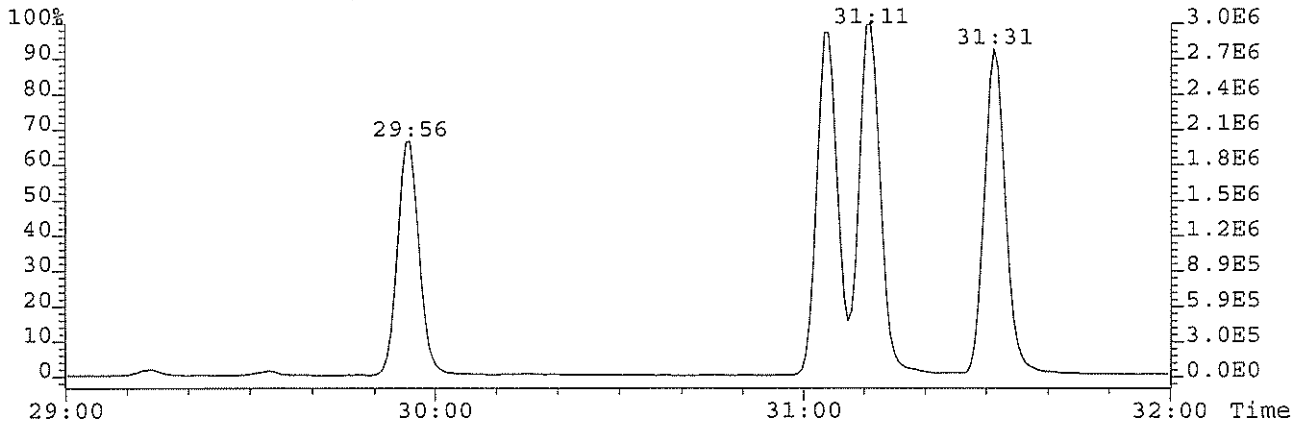
File:130712-2 #1-1116 Acq:12-JUL-2013 23:12:32 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#9 File Text:BPX-DXN(4-6DXN) Text:XB13 0969 Exp:BPX04  
389.8156 S:9 F:2 SMO(1,3)



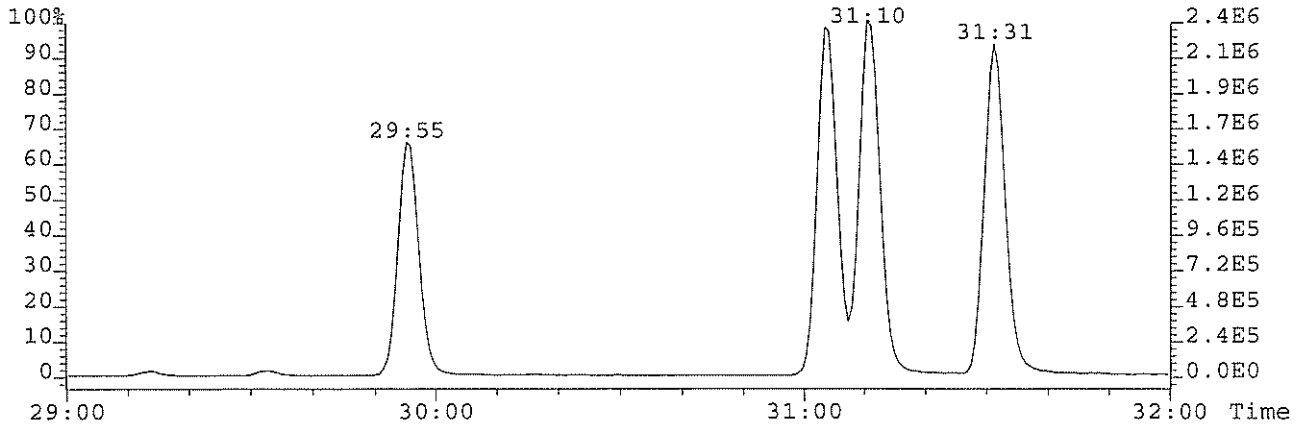
391.8127 S:9 F:2 SMO(1,3)



401.8559 S:9 F:2 SMO(1,3)

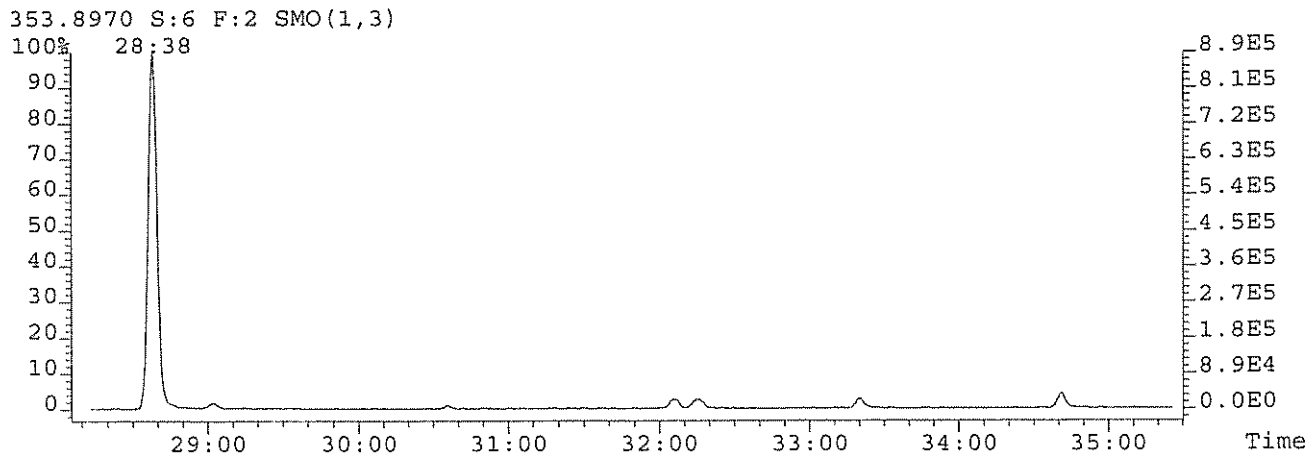
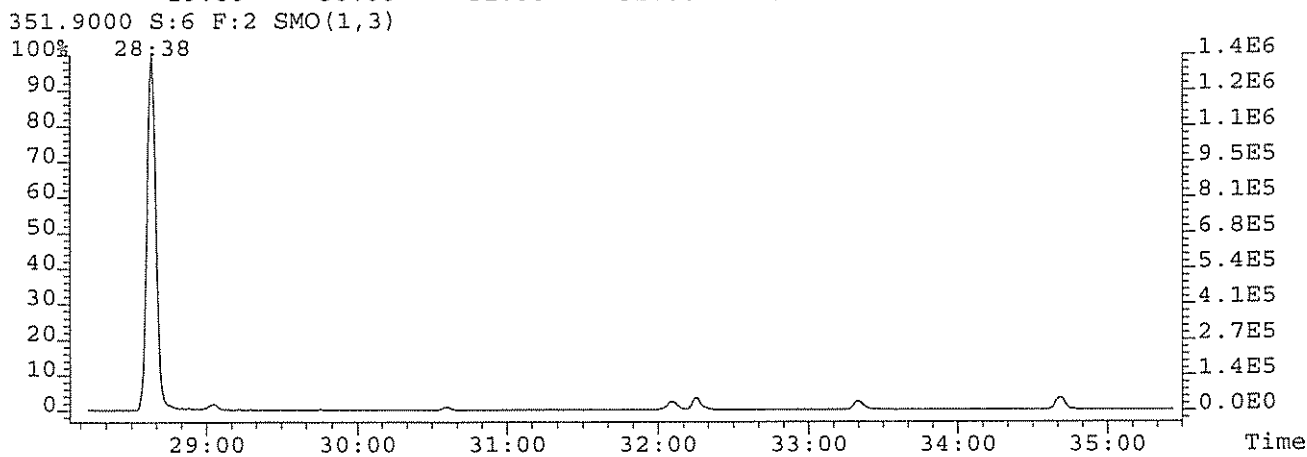
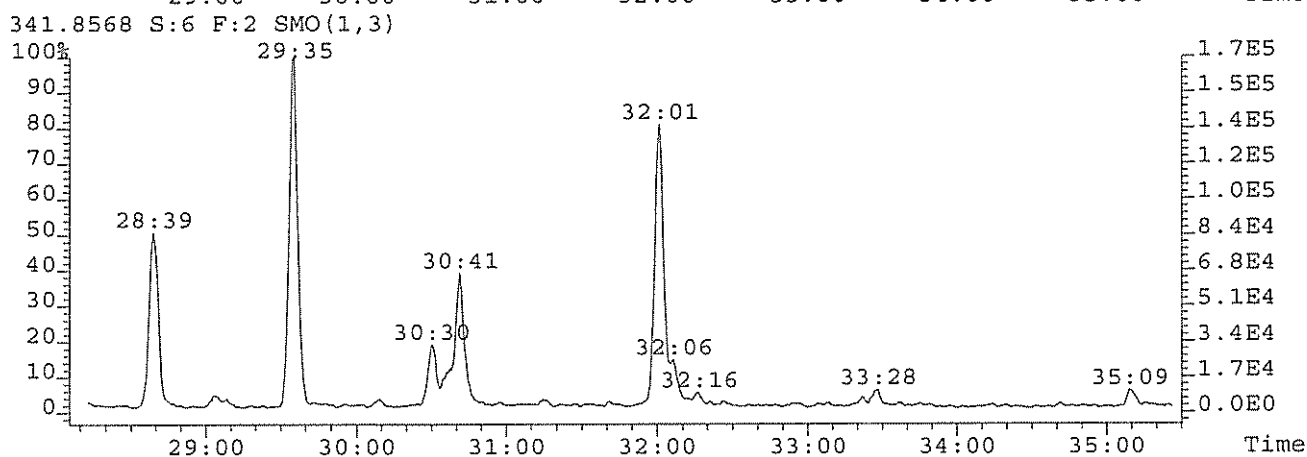
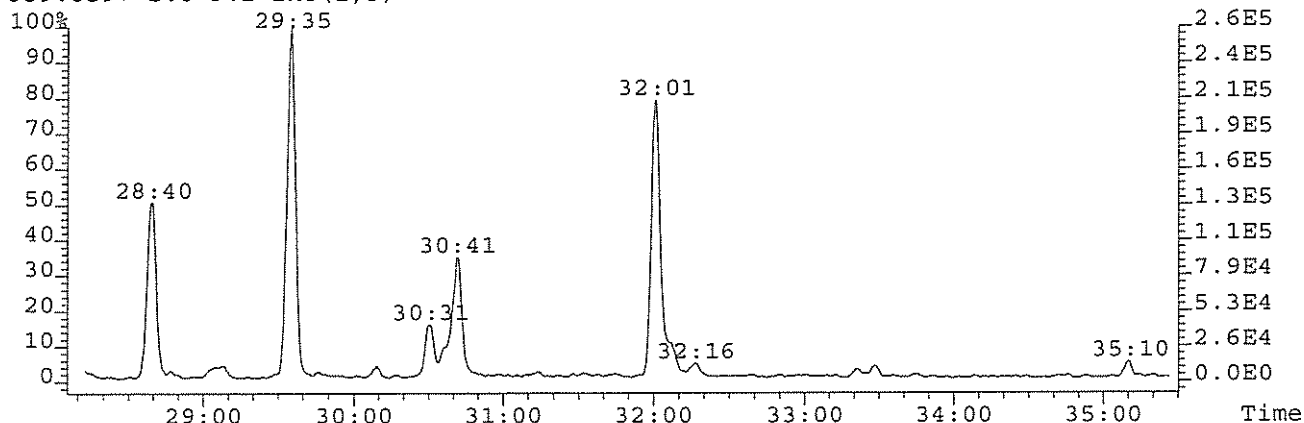


403.8530 S:9 F:2 SMO(1,3)



PCDDsクロマトグラム (6)  
(HxCDDs)

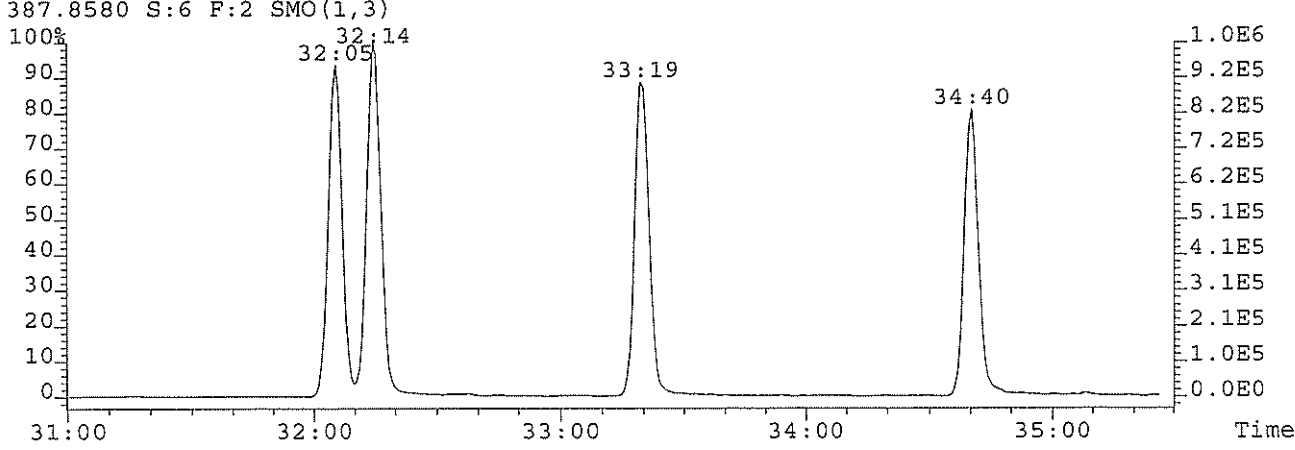
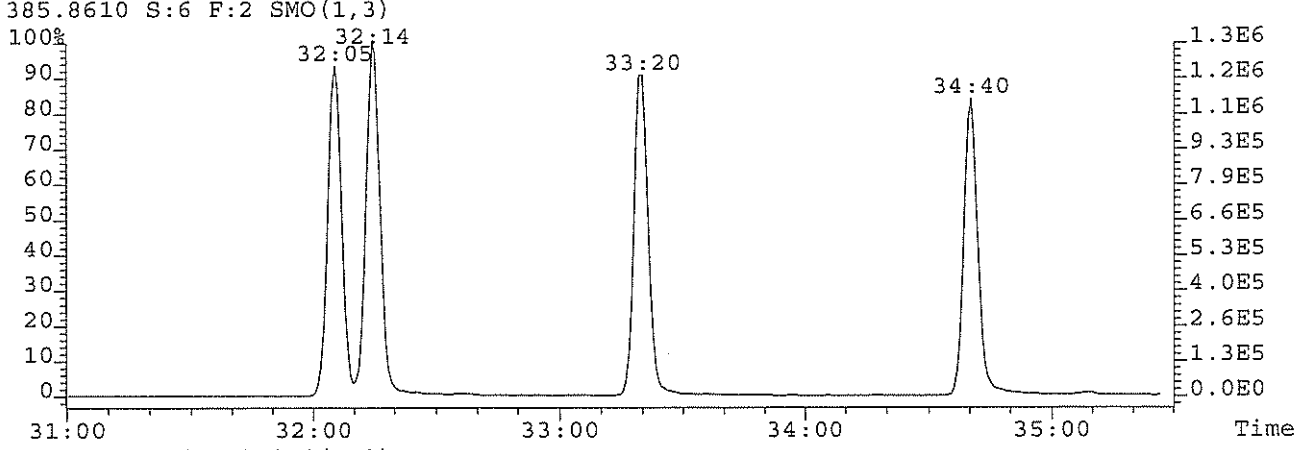
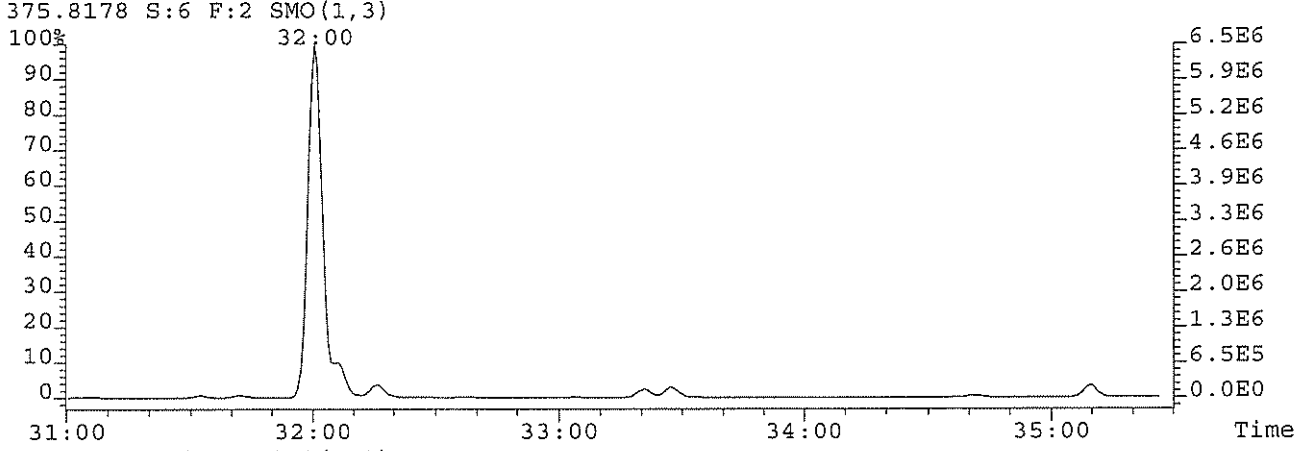
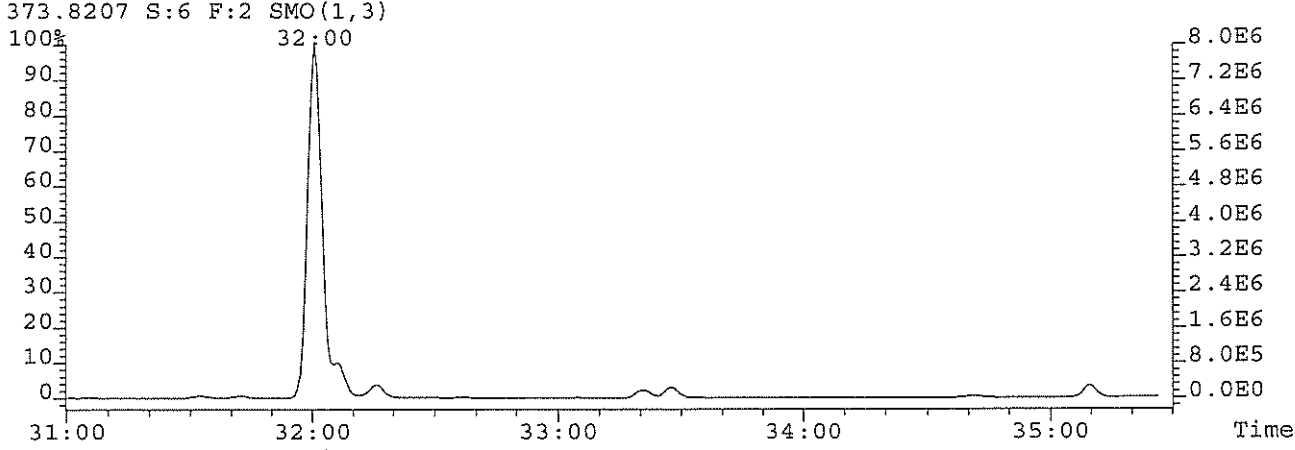
File:130711-2 #1-649 Acq:11-JUL-2013 23:01:37 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#6 File Text:RH-12ms(5-8,nP) Text:XB13 0969 3 Exp:RH-PD22  
339.8597 S:6 F:2 SMO(1,3)



PeCDFsクロマトグラム (7)  
(23478-PeCDF)

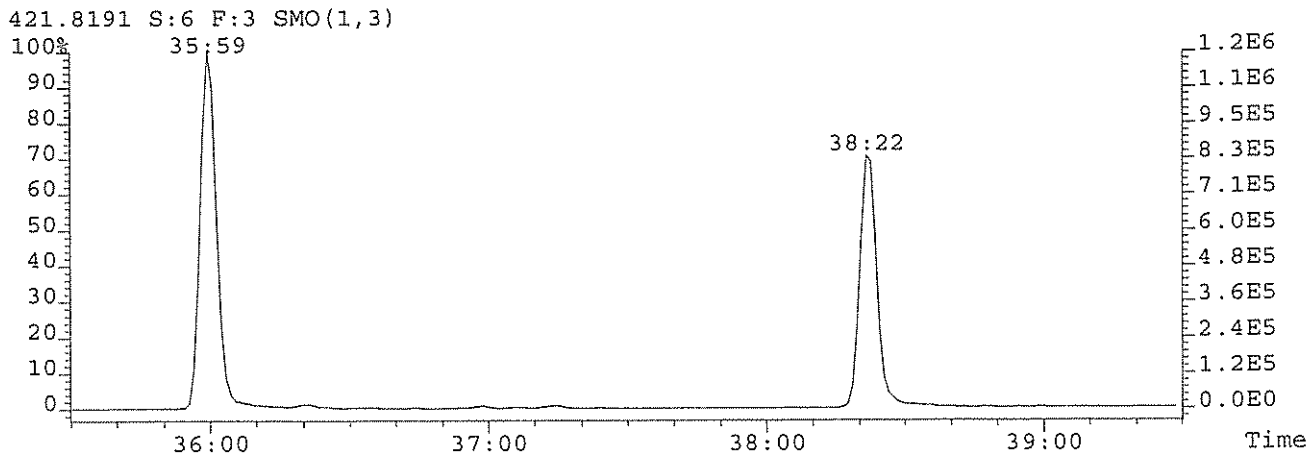
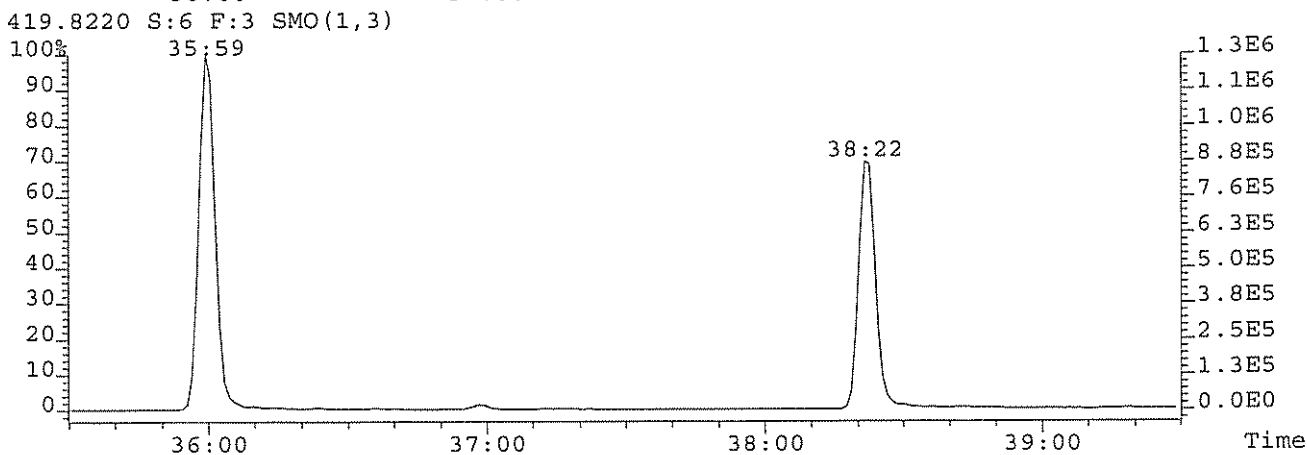
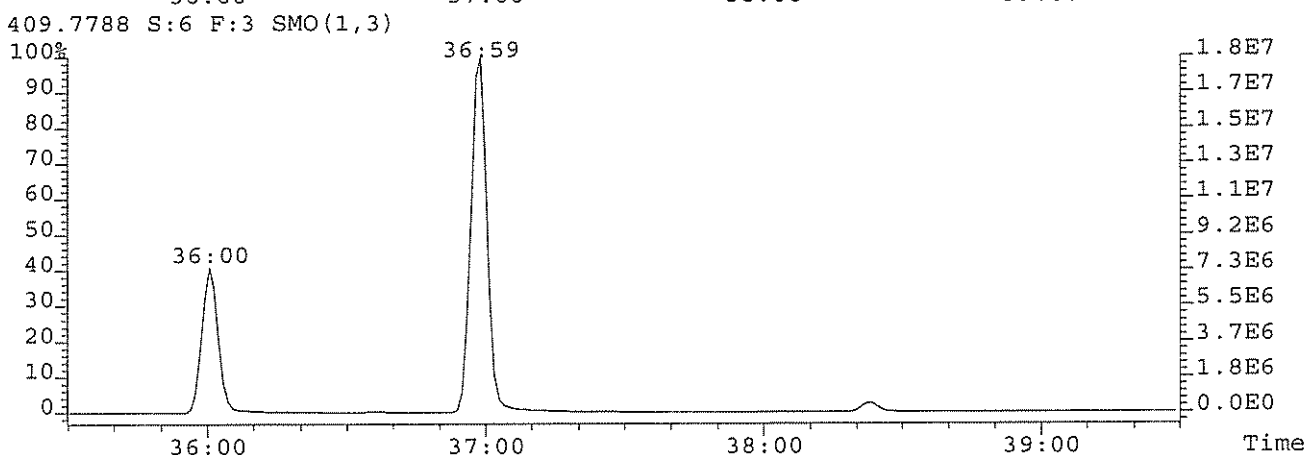
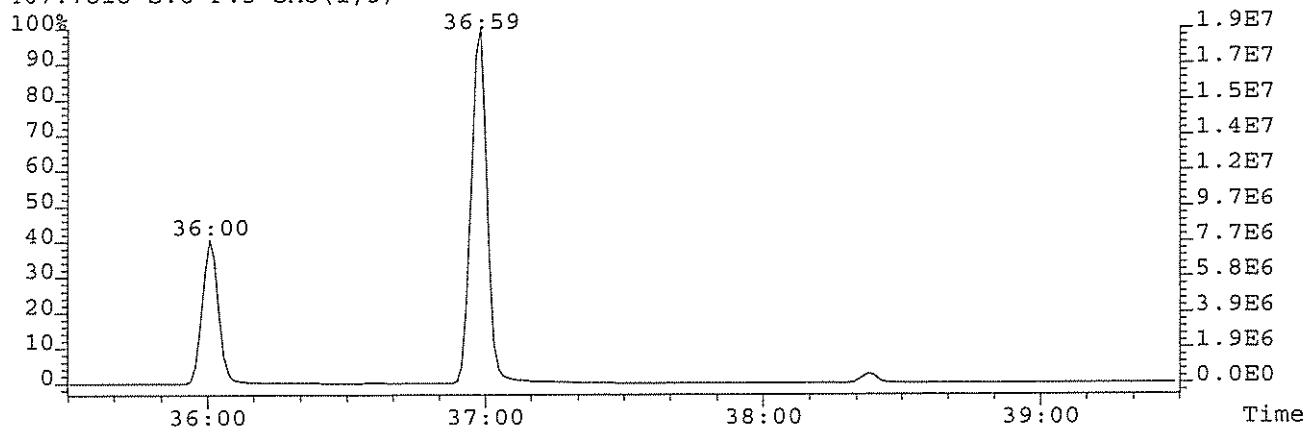


File:130711-2 #1-649 Acq:11-JUL-2013 23:01:37 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#6 File Text:RH-12ms(5-8,nP) Text:XB13 0969 3 Exp:RH-PD22



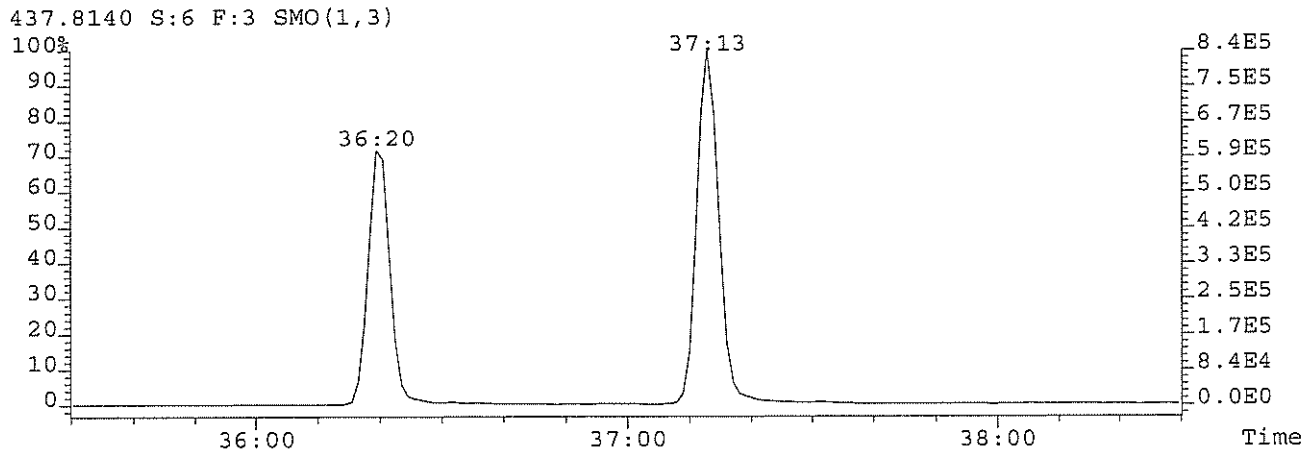
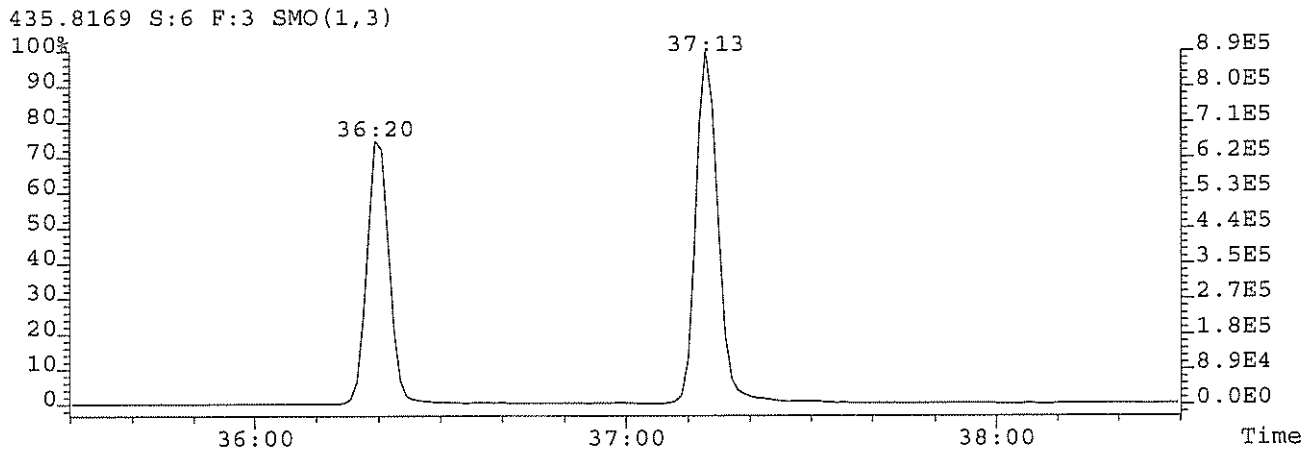
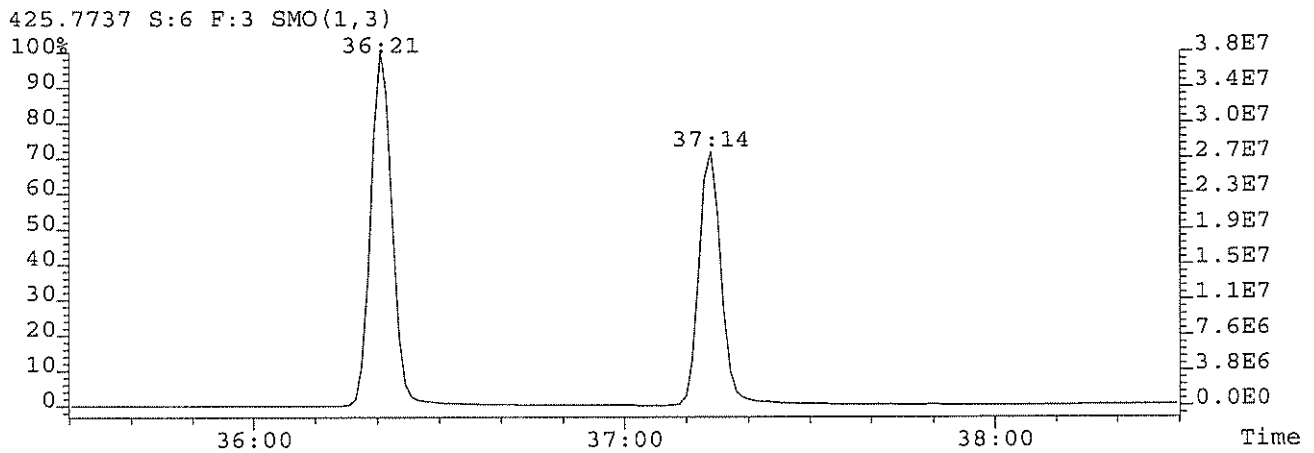
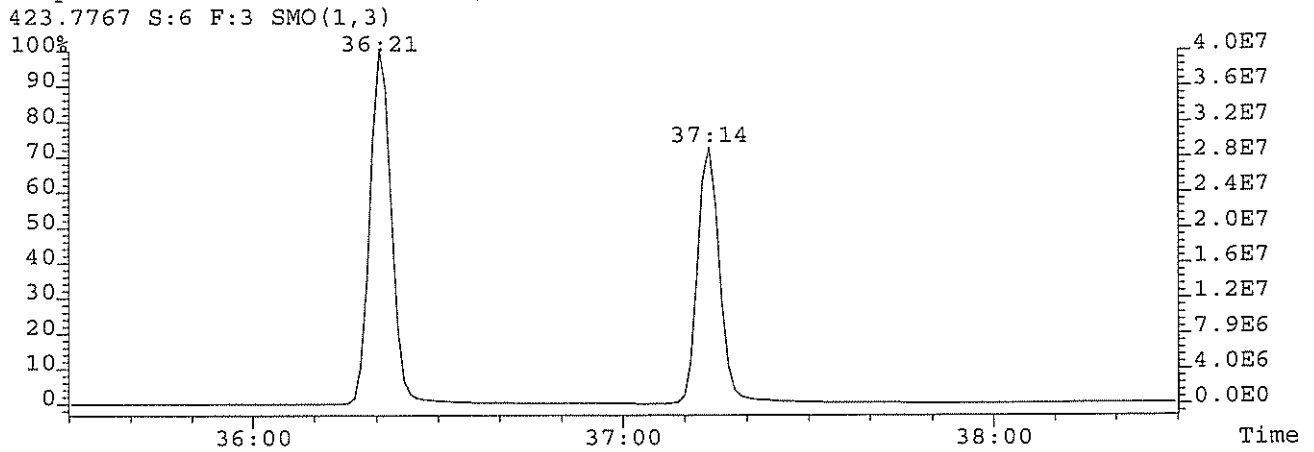
HxCDFsクロマトグラム (8)  
(123789-HxCDF)

File:130711-2 #1-562 Acq:11-JUL-2013 23:01:37 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#6 File Text:RH-12ms(5-8,nP) Text:XB13 0969 3 Exp:RH-PD22  
407.7818 S:6 F:3 SMO(1,3)



PCDFsクロマトグラム (9)  
(HpCDFs)

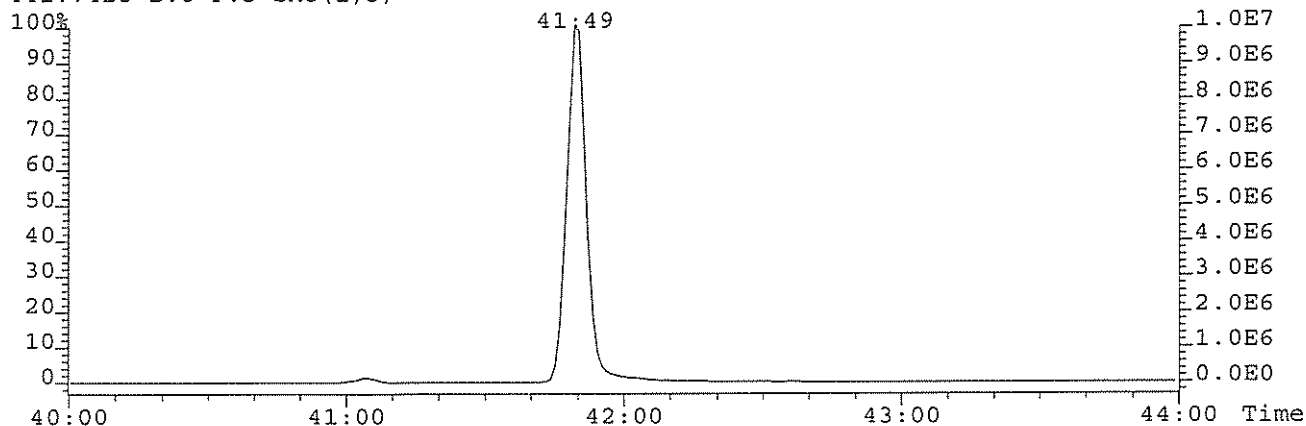
File:130711-2 #1-562 Acq:11-JUL-2013 23:01:37 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#6 File Text:RH-12ms(5-8,nP) Text:XB13 0969 3 Exp:RH-PD22



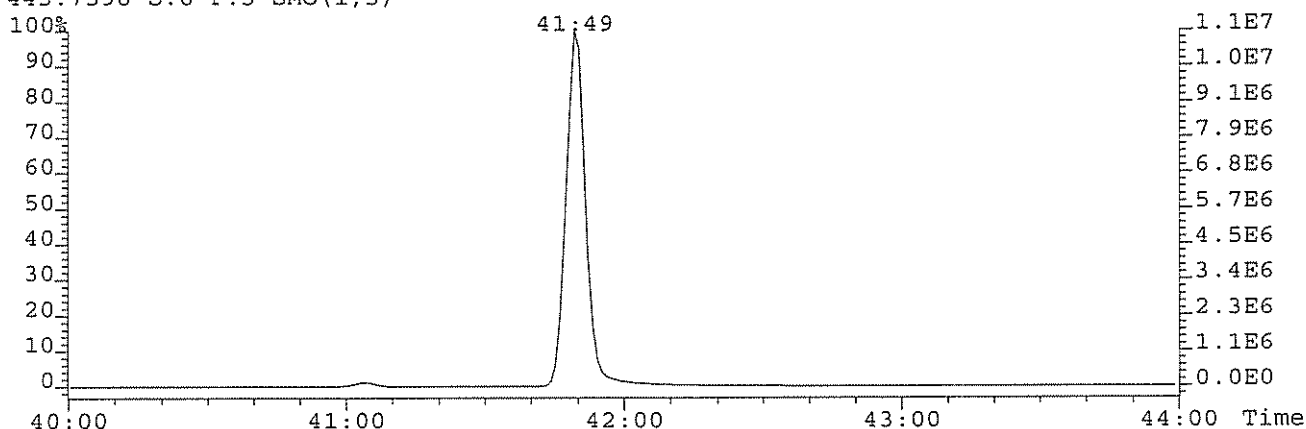
PCDDsクロマトグラム (10)  
(HpCDDs)

File:130711-2 #1-562 Acq:11-JUL-2013 23:01:37 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#6 File Text:RH-12ms(5-8,nP) Text:XB13 0969 3 Exp:RH-PD22

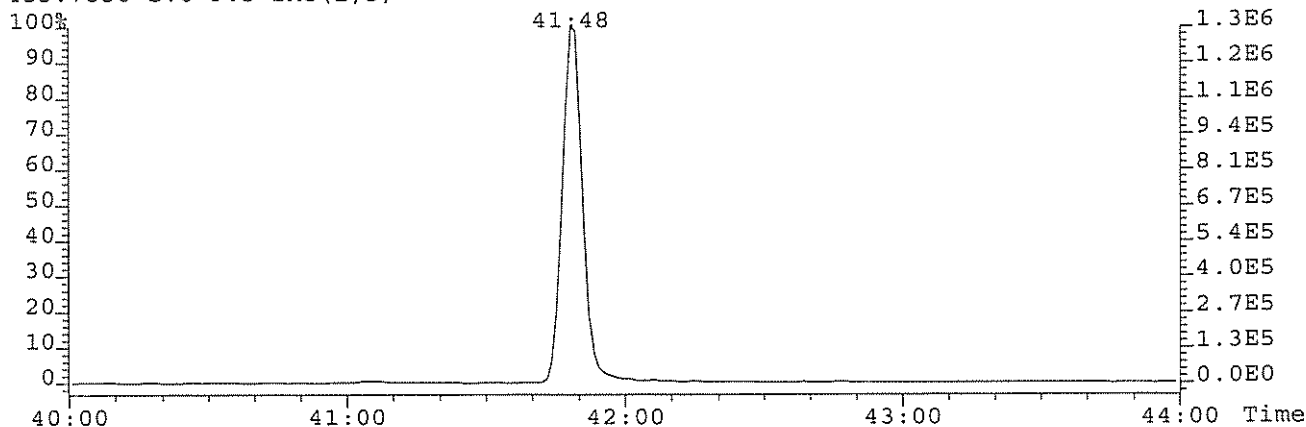
441.7428 S:6 F:3 SMO(1,3)



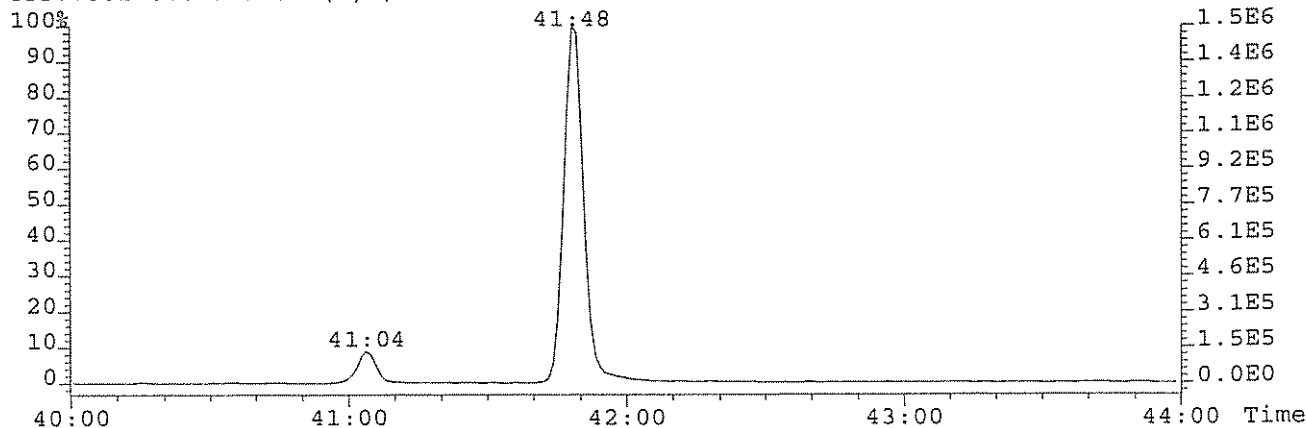
443.7398 S:6 F:3 SMO(1,3)



453.7830 S:6 F:3 SMO(1,3)



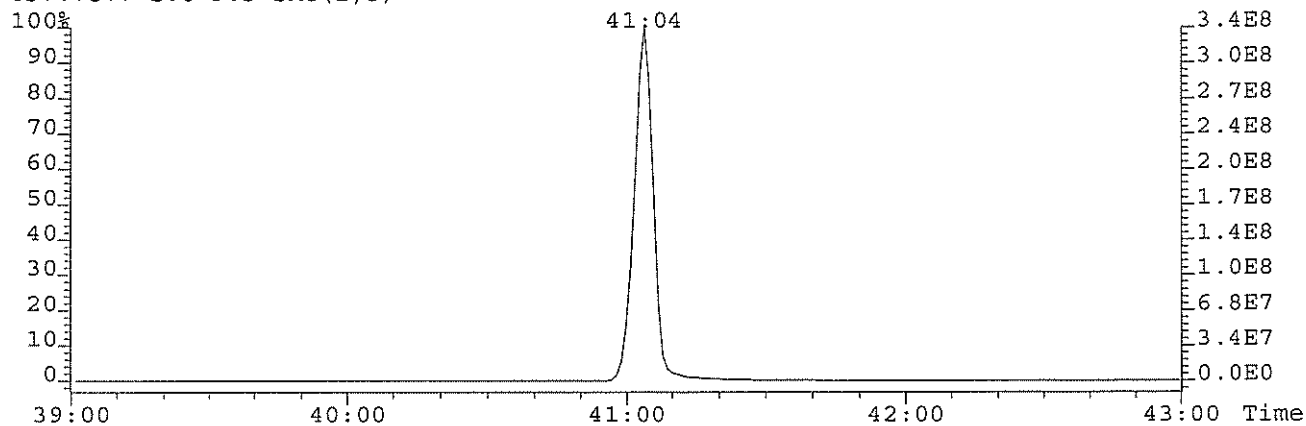
455.7801 S:6 F:3 SMO(1,3)



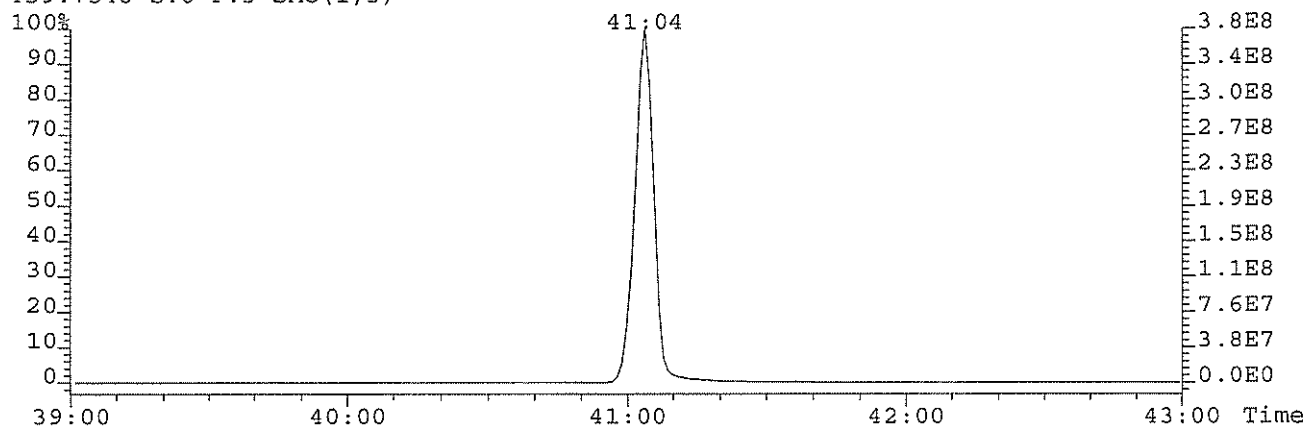
PCDFsクロマトグラム (11)  
(OCDF)

File:130711-2 #1-562 Acq:11-JUL-2013 23:01:37 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#6 File Text:RH-12ms(5-8,nP) Text:XB13 0969 3 Exp:RH-PD22

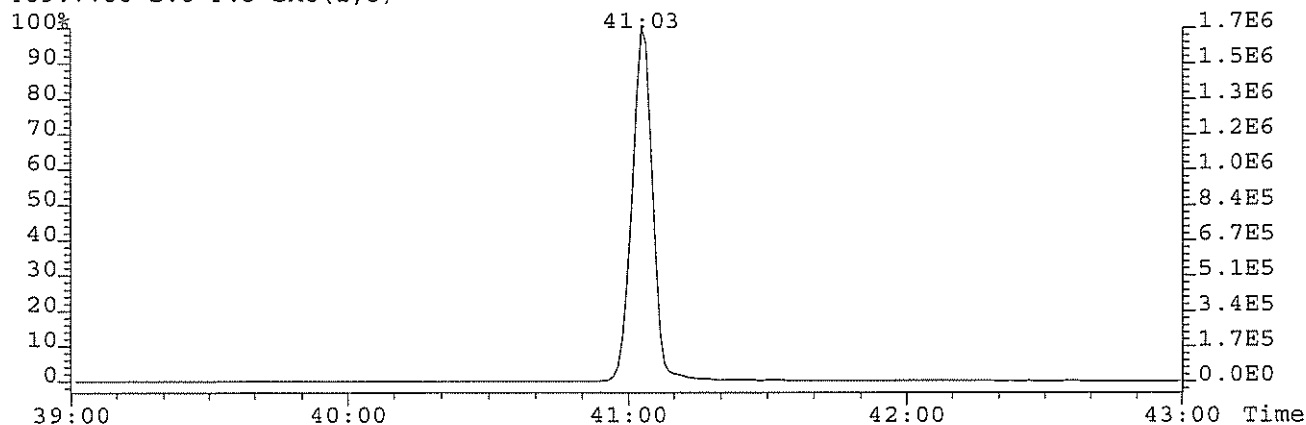
457.7377 S:6 F:3 SMO(1,3)



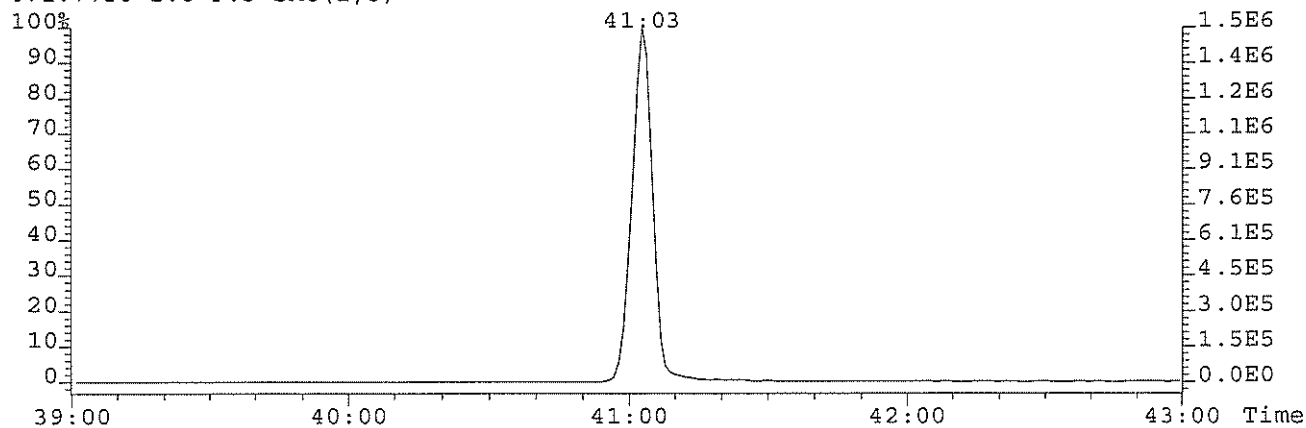
459.7348 S:6 F:3 SMO(1,3)



469.7780 S:6 F:3 SMO(1,3)

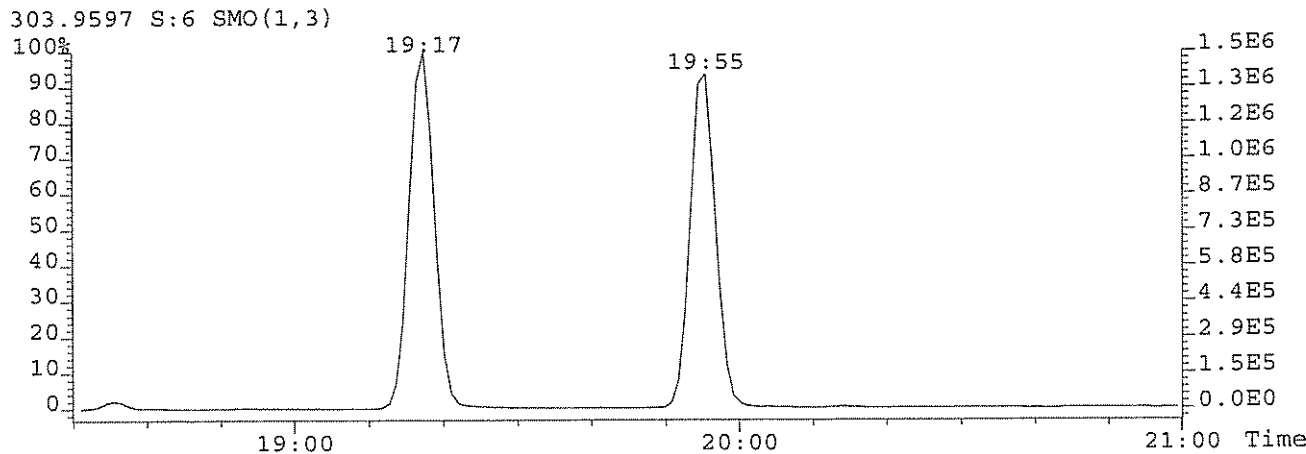
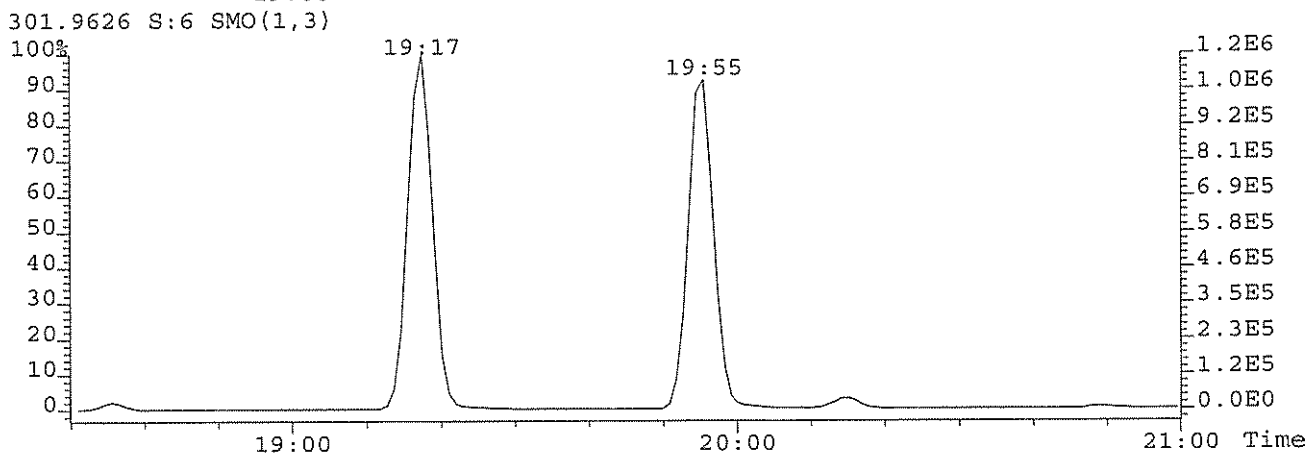
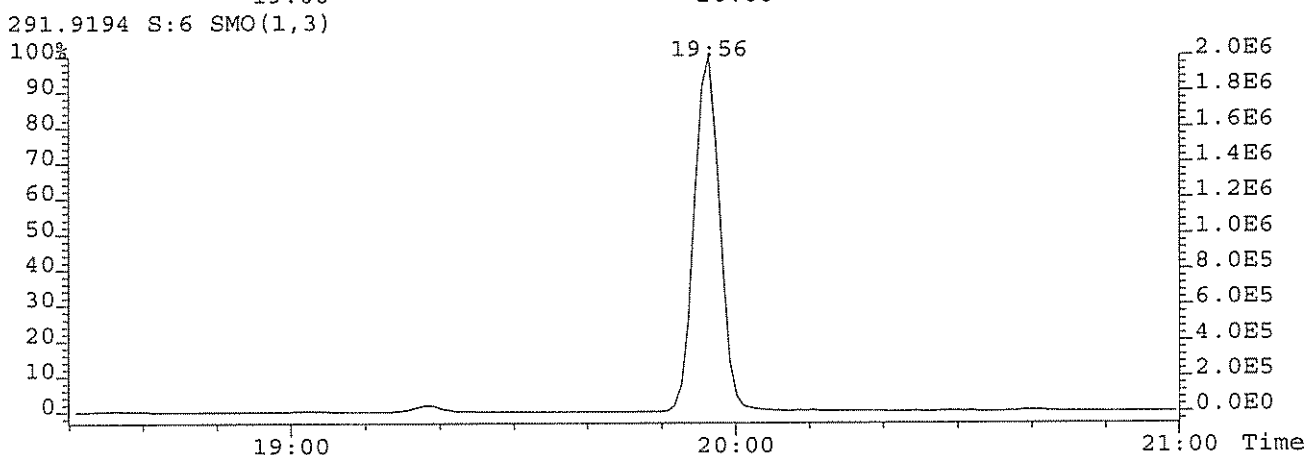
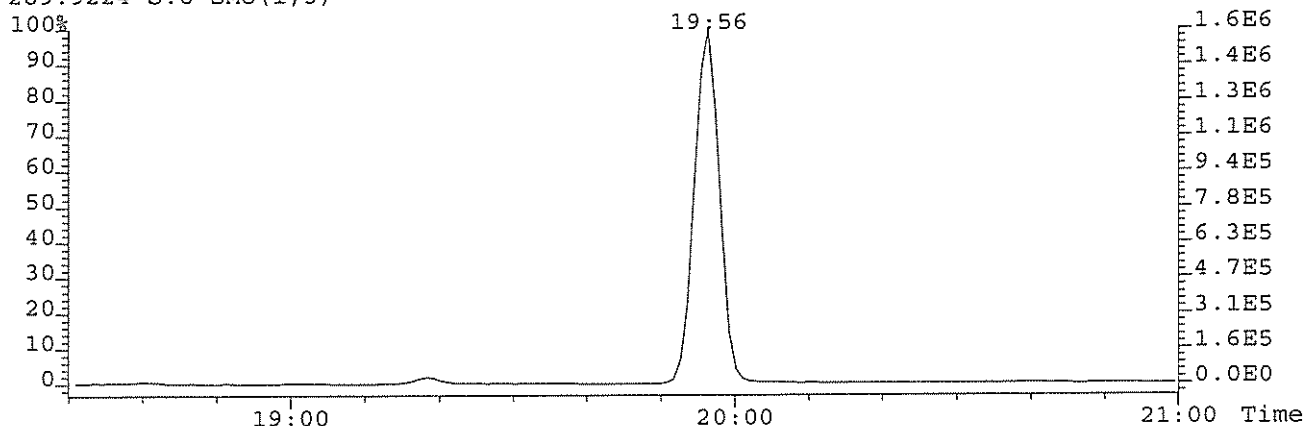


471.7750 S:6 F:3 SMO(1,3)



PCDDsクロマトグラム (12)  
(OCDD)

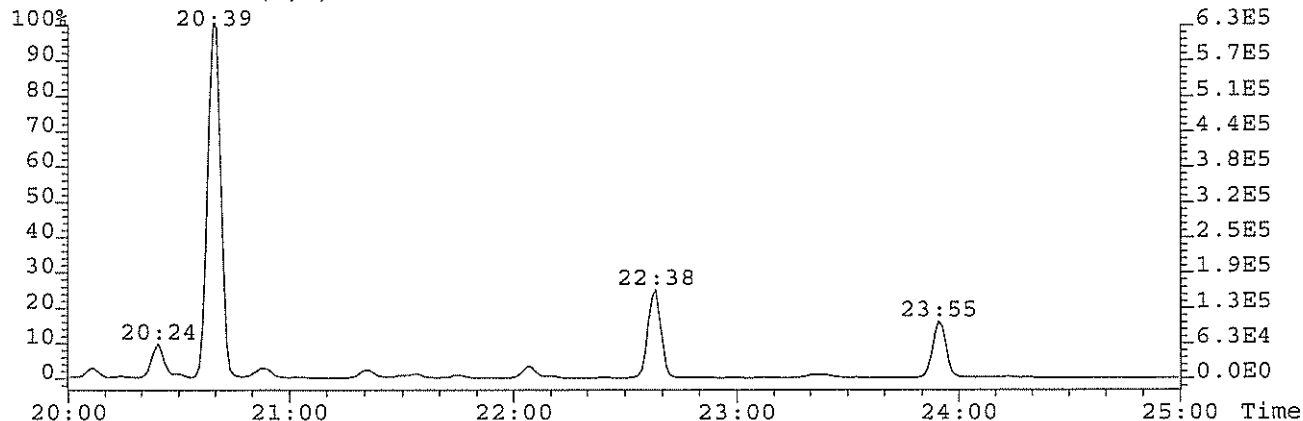
File:130711-2 #1-1430 Acq:11-JUL-2013 23:01:37 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#6 File Text:RH-12ms(5-8,nP) Text:XB13 0969 3 Exp:RH-PD22  
289.9224 S:6 SMO(1,3)



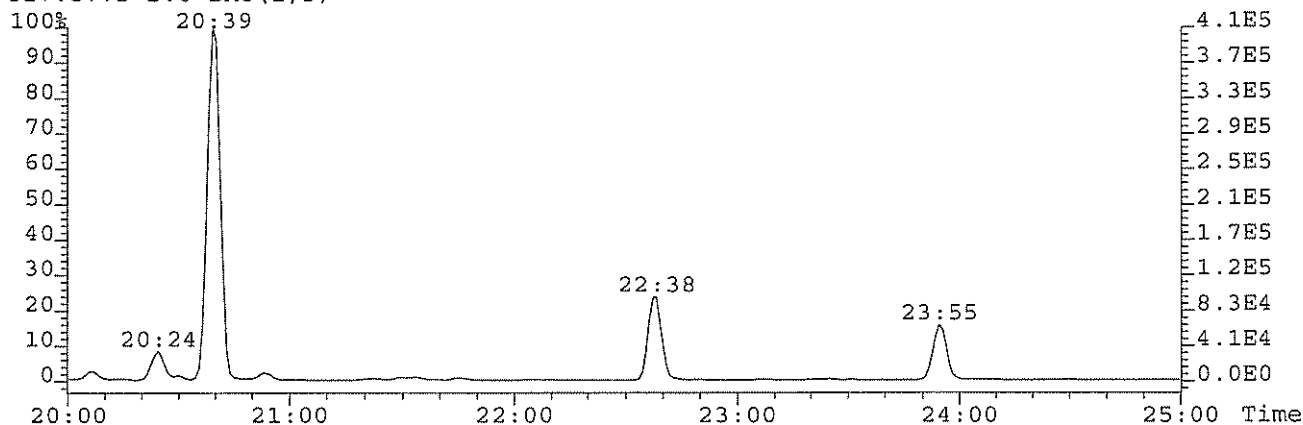
DL-PCBクロマトグラム (13)  
(Non-ortho TeCBs)

File:130711-2 #1-1430 Acq:11-JUL-2013 23:01:37 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#6 File Text:RH-12ms(5-8,nP) Text:XB13 0969 3 Exp:RH-PD22

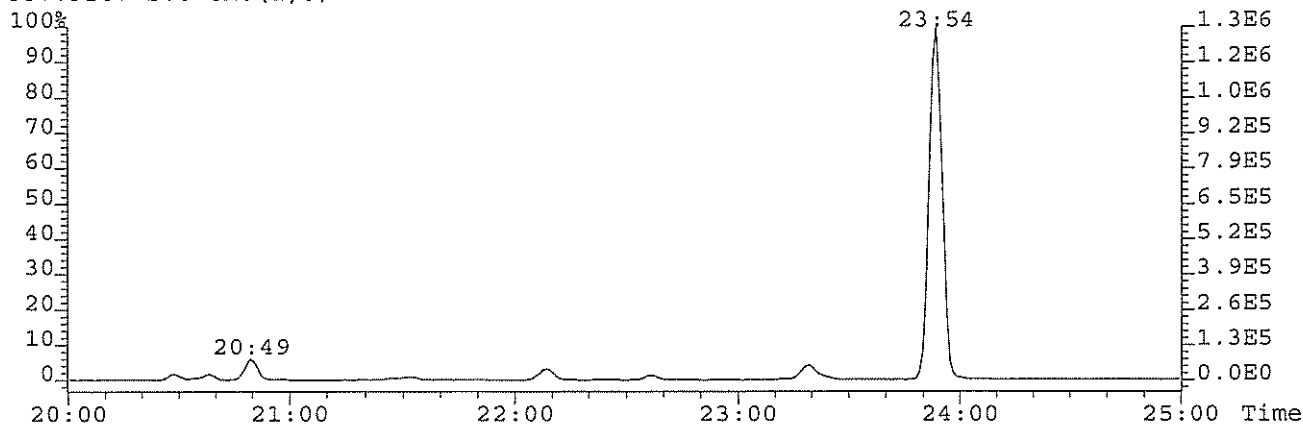
325.8804 S:6 SMO(1,3)



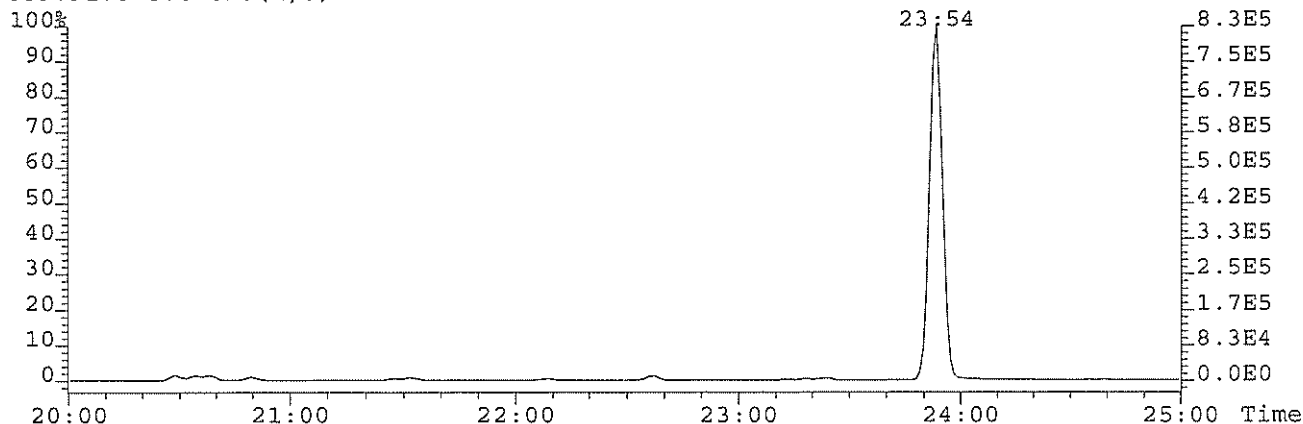
327.8775 S:6 SMO(1,3)



337.9207 S:6 SMO(1,3)

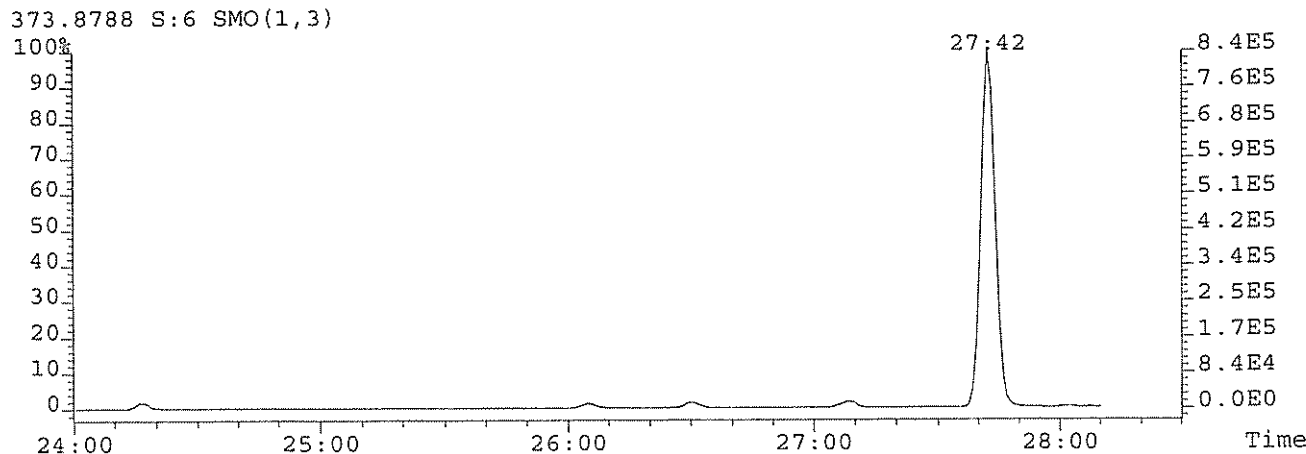
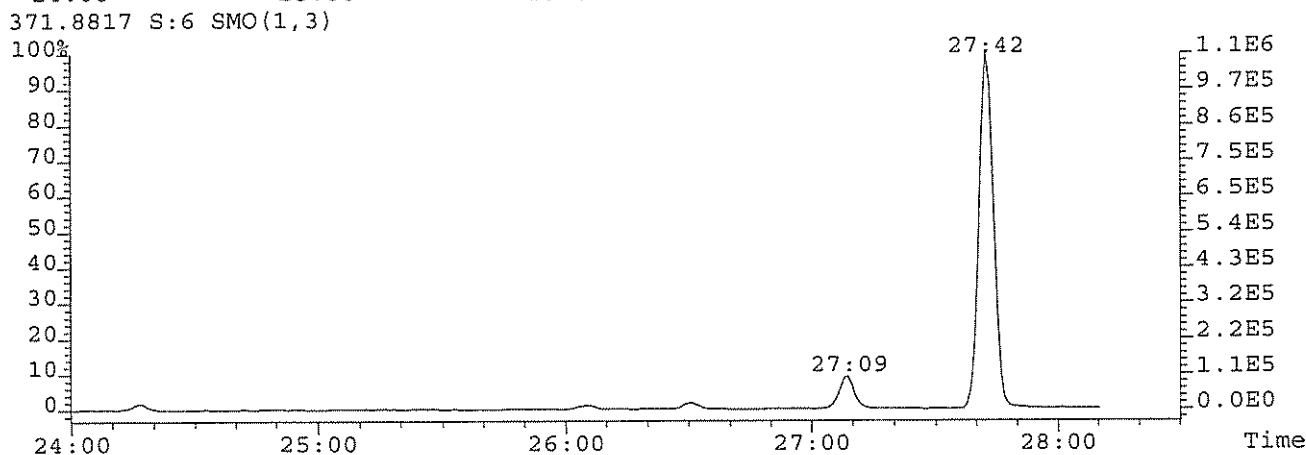
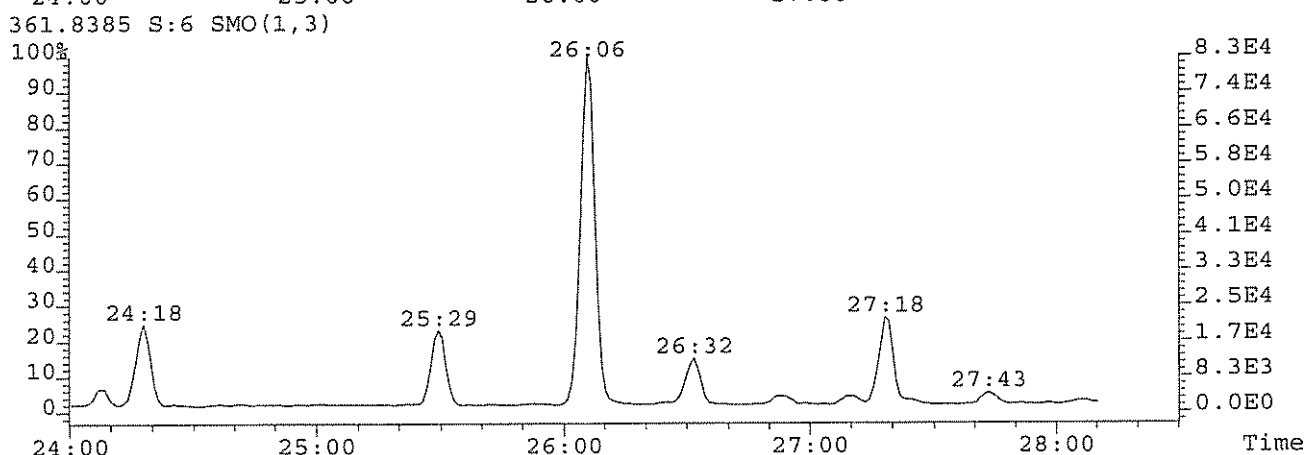
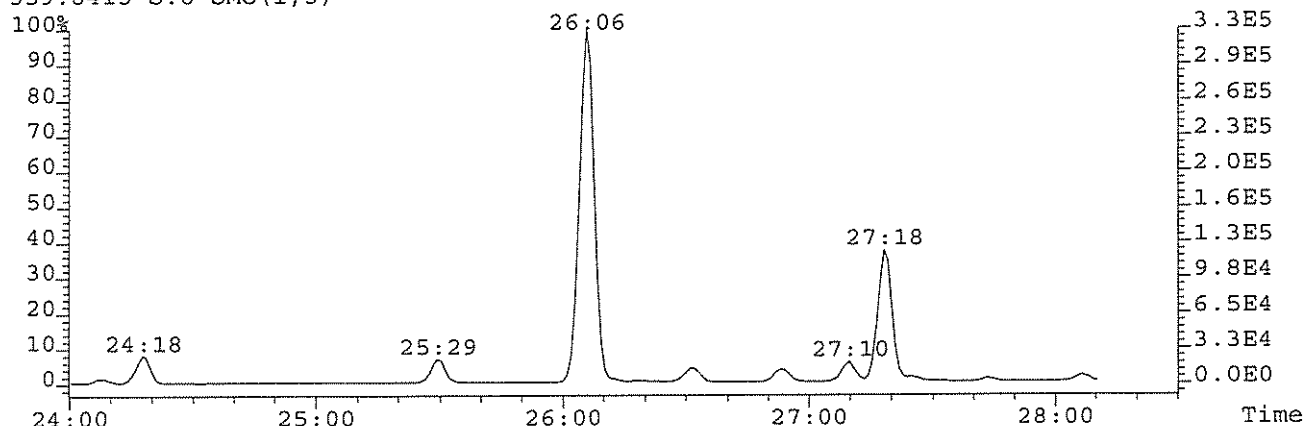


339.9178 S:6 SMO(1,3)



DL-PCBクロマトグラム (14)  
(Non-ortho PeCBs)

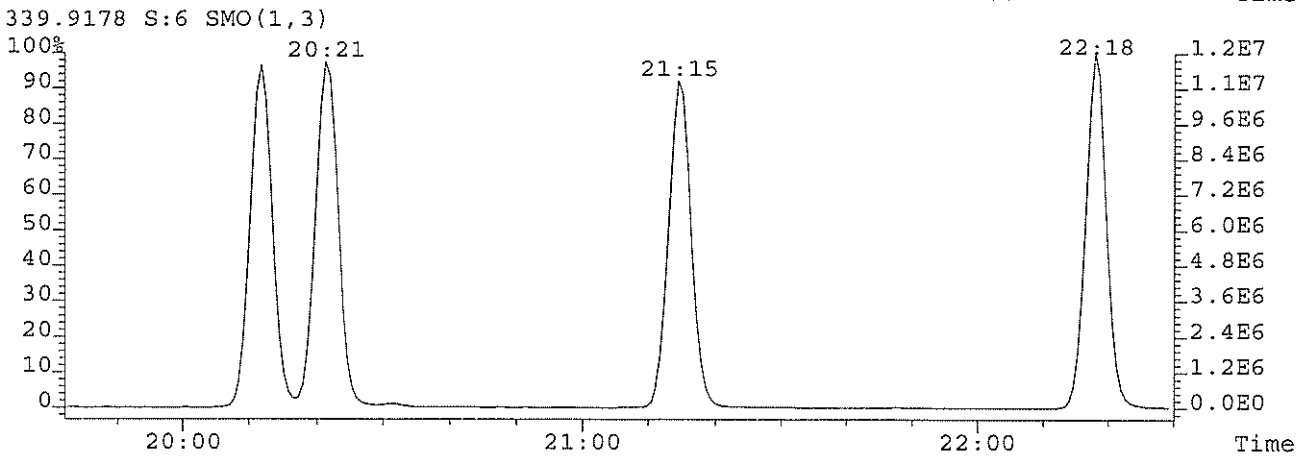
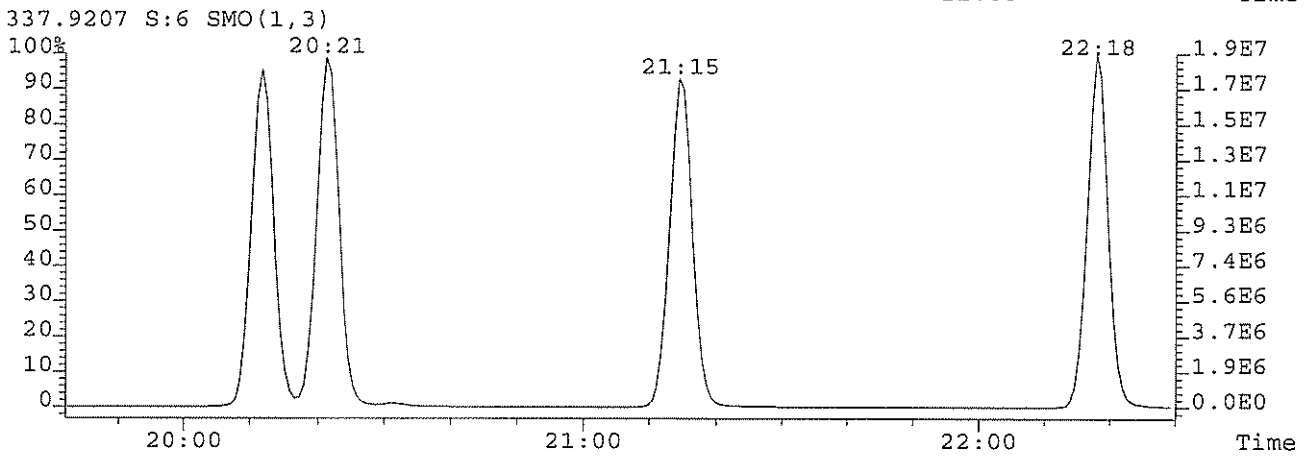
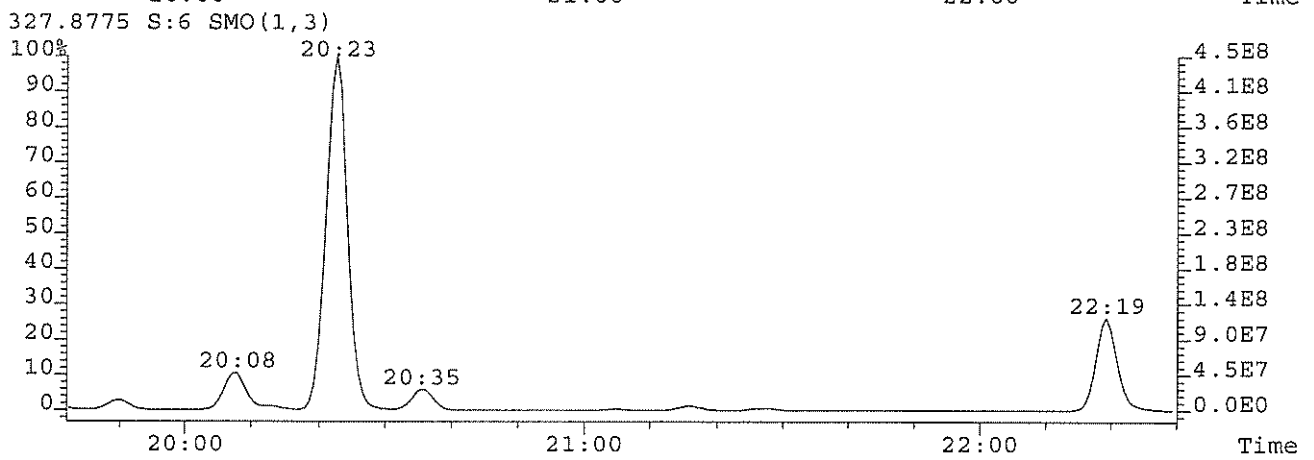
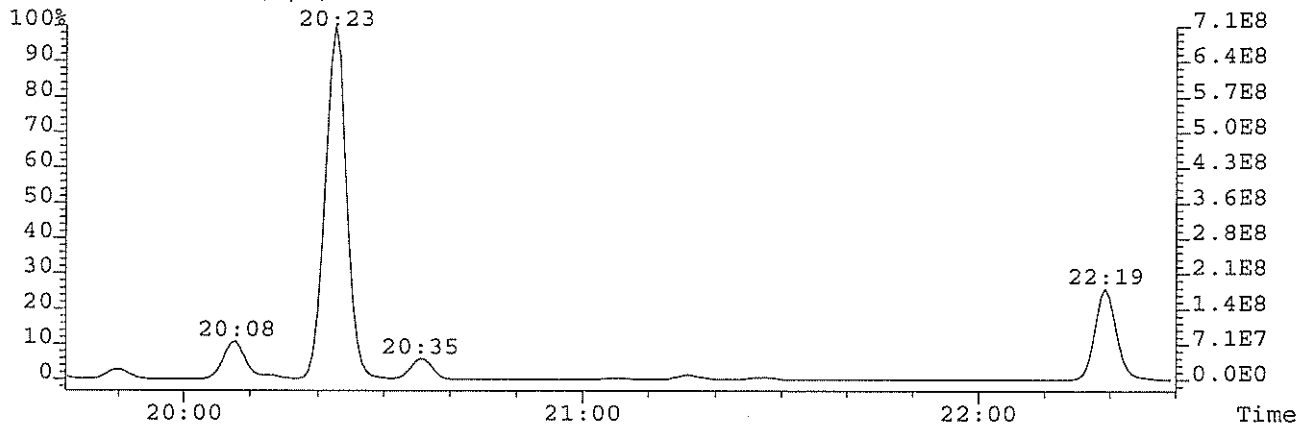
File:130711-2 #1-1430 Acq:11-JUL-2013 23:01:37 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#6 File Text:RH-12ms(5-8,nP) Text:XB13 0969 3 Exp:RH-PD22  
359.8415 S:6 SMO(1,3)



DL-PCBクロマトグラム (15)  
(Non-ortho HxCBs)

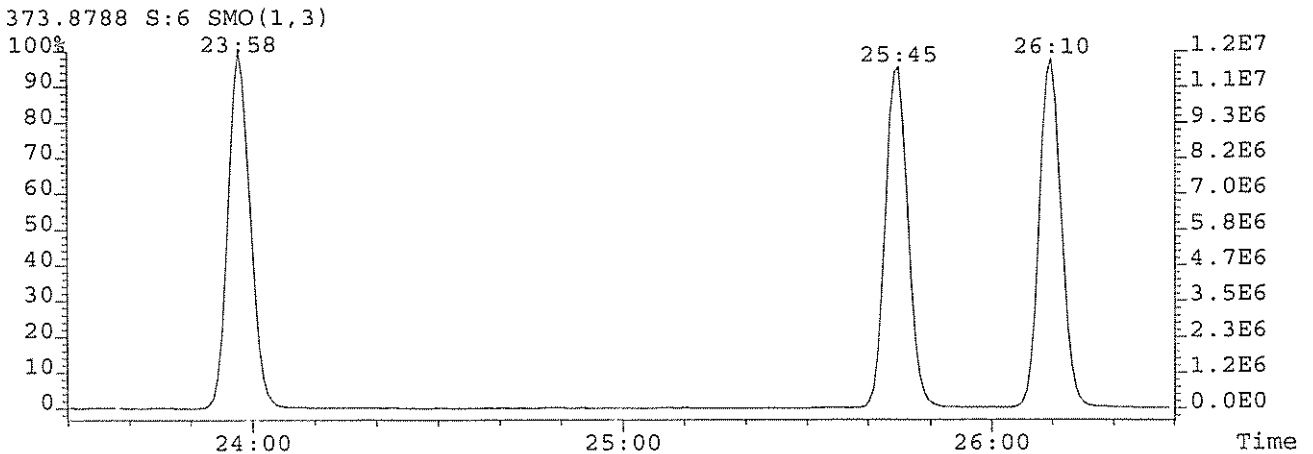
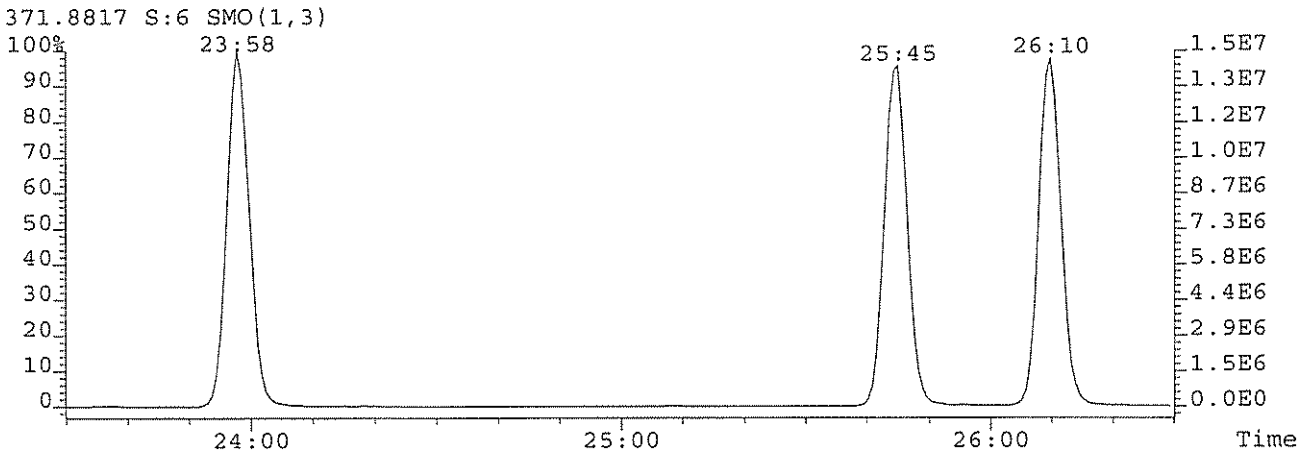
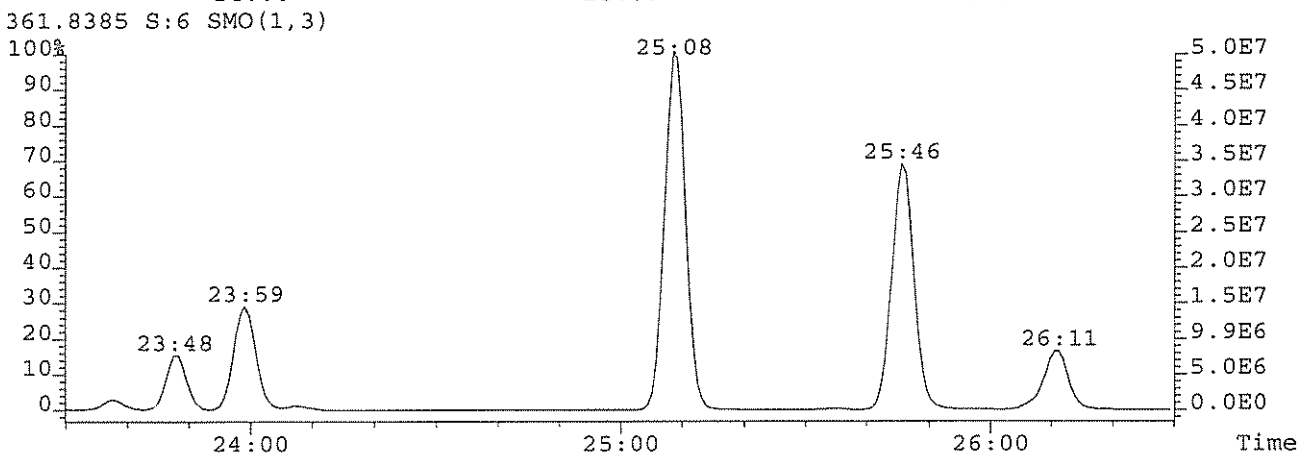
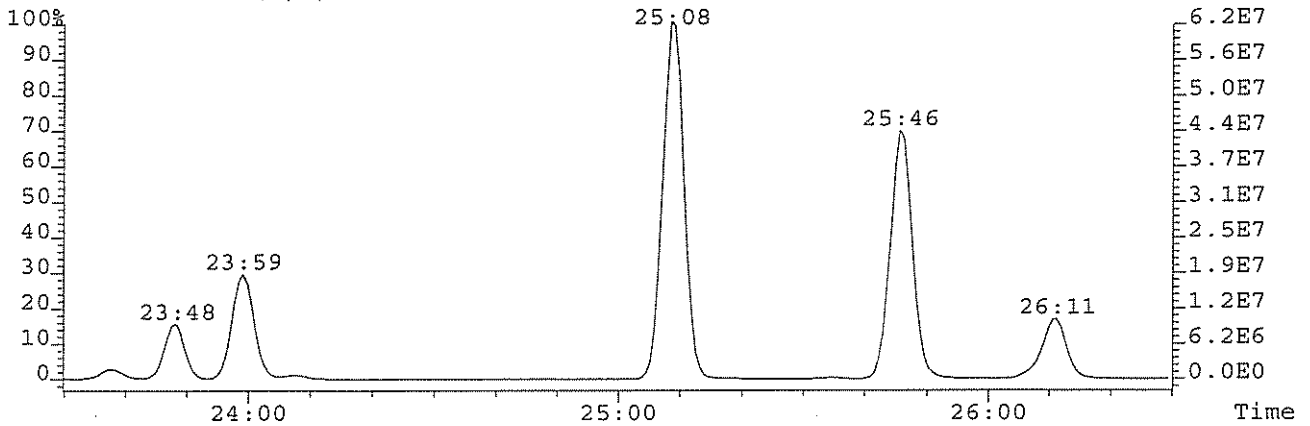


File:130711-2 #1-2898 Acq:11-JUL-2013 21:20:17 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#6 File Text:RH-12ms(mP) Text:XB13 0969 2 Exp:RH-MP11  
325.8804 S:6 SMO(1,3)



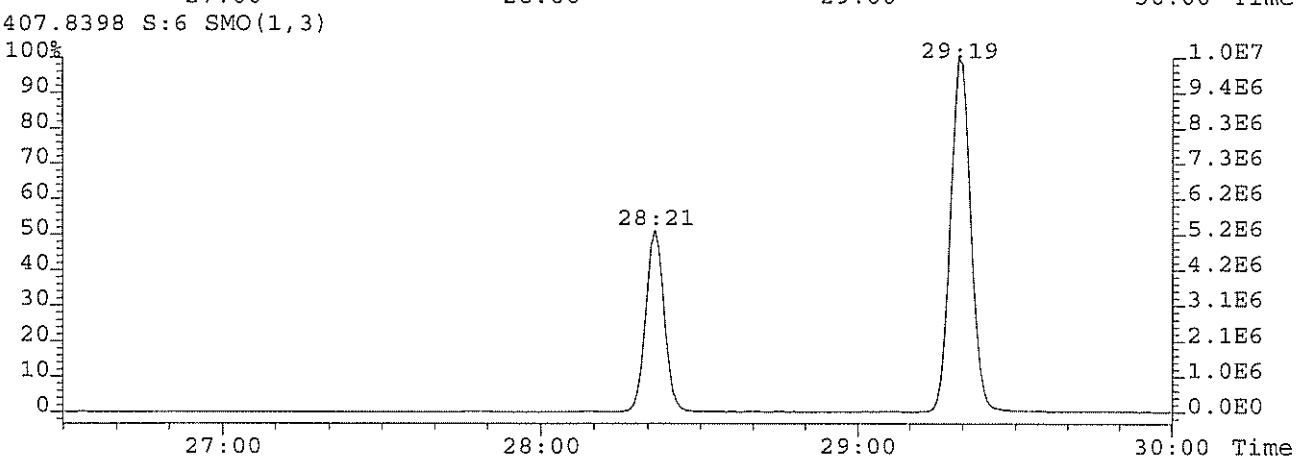
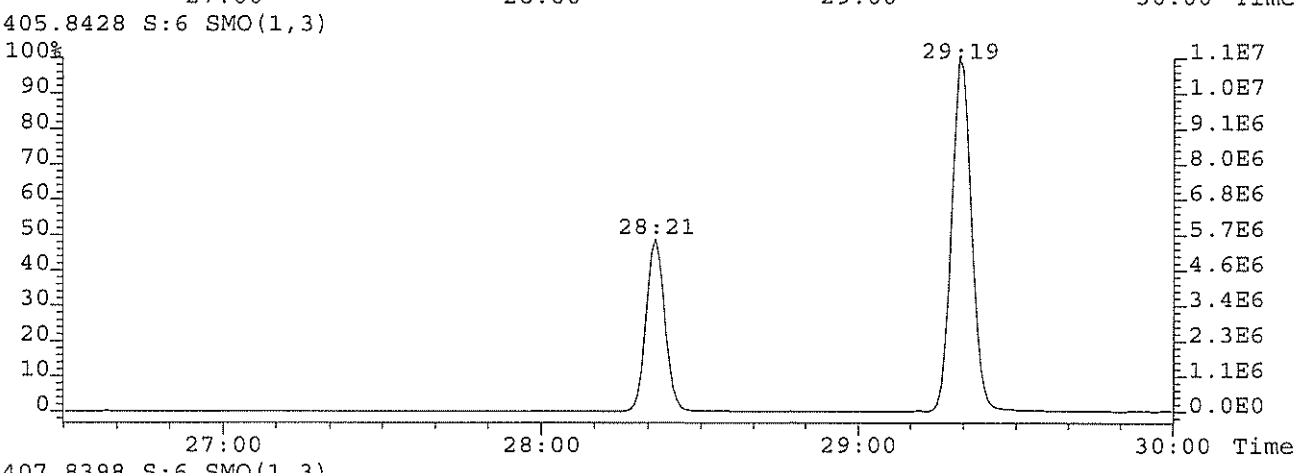
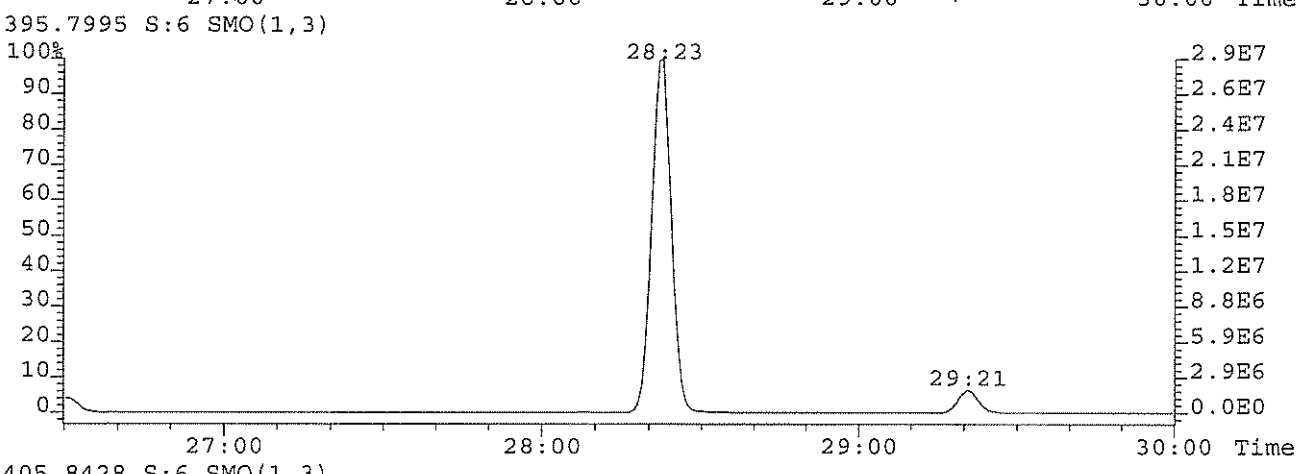
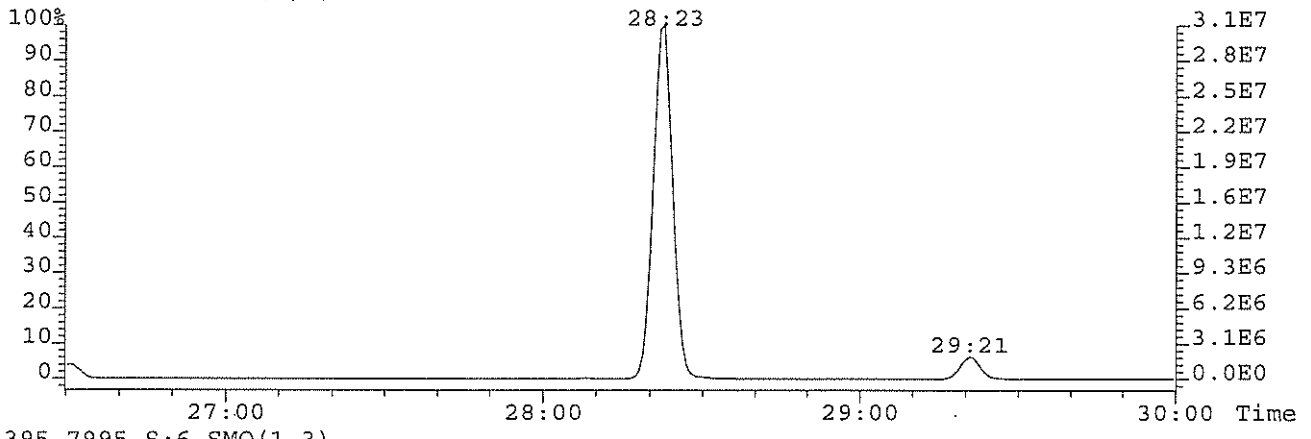
DL-PCBクロマトグラム (16)  
(Mono-ortho PeCBs)

File:130711-2 #1-2898 Acq:11-JUL-2013 21:20:17 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#6 File Text:RH-12ms(mP) Text:XB13 0969 2 Exp:RH-MP11  
359.8415 S:6 SMO(1,3)



DL-PCBクロマトグラム (17)  
(Mono-ortho HxCBs)

File:130711-2 #1-2898 Acq:11-JUL-2013 21:20:17 GC EI+ Voltage SIR Autospec-UltimaE  
Sample#6 File Text:RH-12ms(mP) Text:XB13 0969 2 Exp:RH-MP11  
393.8025 S:6 SMO(1,3)



DL-PCBクロマトグラム (18)  
(Mono-ortho HpCBs)